# INTERFACE BIPOLAR LSI BIPOLAR MEMORY PROGRAMMABLE LOGIC DATABOOK

NATIONAL
SEMICONDUCTOR
CORPORATION



# INTERFACE BIPOLAR LSI BIPOLAR MEMORY PROGRAMMABLE LOGIC DATA BOOK

DATABOOK
Transmission Line Drivers/Receivers
Bus Transceivers
Peripheral/Power Drivers
Level Translators/Buffers
Display Controllers/Drivers
Memory Support
Dynamic Memory Support
Microprocessor Support
Data Communications Support
Disk Support
Frequency Synthesis
nterface Appendices
Bipolar PROMs
Bipolar and ECL RAMs
2900 Family/Bipolar Microprocessor

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All physical dimensions appear at the end of the databook.

**Programmable Logic** 



#### Introduction

The 1983 edition of the National Semiconductor Interface / Bipolar LSi / Bipolar Memory / Programmable Logic Databook is the most comprehensive available. It contains complete specifications on these high technology products, as well as applications information, product selection and cross reference guides.

#### **Quality and Reliability**

As electronic systems become more and more complex, the need for consistently high quality integrated circuits becomes increasingly important. Having recognized this need as far back as the 1970s, National Semiconductor initiated a unique, company-wide Quality Improvement Program. The results have been dramatic and, we believe, unmatched in this industry. Over the years, National has regularly been named by many major customers as "Quality Manufacturer of the Year." We are proud of our success, which sets a standard for others to achieve. And yet our quest for perfection is ongoing, so that customers can continue to rely on National Semiconductor integrated circuits and products in their system designs.



#### Einführung

Die 1983er Ausgabe des National Semiconductor Interface/Bipolar LSI/Bipolar Memory/Programmable Logic Datenbuches ist die umfassendste Ausgabe die jemals zur verfügung stand. Sie beinhaltet komplette Spezifikationen dieser hochtechnologischen Produkte so wie Angaben über Anwendungsmöglichkeiten, Produktselektion und Referenzlisten.

#### Qualität und Zuverlässigkeit

Mit der zunehmenden Komplexität der elektronischen Systeme wird die Notwendigkeit integriete Schaltungen mit hoher Qualität immer wichtiger. Dies bereits in den 70lger Jahren erkannt, entwickelte National Semiconductor ein einmaliges, firmenweites "Qualitätsverbesserungsprogramm". Die damit von National Semiconductor erreichten Ergebnisse sind bis heute—wie wir glauben—unerreicht. Während der letzten Jahre wurde National Semiconductor regelmässig als "Qualitätshersteller Nr 1" bewertet. Auf diesen Erfolg sind wir stolz. Er setzt neue Mass-Stäbe für die Industrie. Und doch gehen unsere Austrengungen zu immer höheren Perfektion weiter, so dass sich unsere Kunden auch in Zukunft auf National Semiconductor's integriete Schaltungen und Produkte in ihren Systemen absolut verlassen können.

#### Introduction

L'edition 1983 du catalogue National Semiconductor Interface/Bipolar LSI/Bipolar Memory/Programmable Logic est le plus accessible des catalogues disponibles. Le contenu de cette édition spécifie complétement ces produits à technologie de pointe et décrit des examples d'application, plus une selection de produits avec une liste de correspondance.

#### Qualité et Fiabilité

La complexité croissante des systèmes electroniques demande des circuits intégrés de plus en plus haute qualité. Conscient de ce besoin dès les années '70 National Semiconductor fut à l'origine d'un programme unique accentuant la qualité de tous ses produits. Les résultats furent spectaculaires et inégalés. Depuis National Semiconductor a regu la distinction pour la qualité de ses produits de la part de ses clients. Nous sommes fiers de ce succès qui force les autres à suivre nos standarts. Notre recherche de la perfection se poursuit apportant la confiance pour nos clients en nos produits et leur utilisation pour leurs systèmes.

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- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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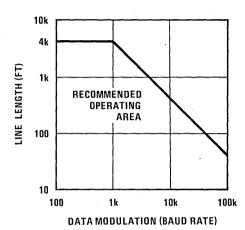
# Section 1 Transmission Line Drivers/Receivers



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<sup>\*</sup>Also available screened in accordance with MIL-STD-883 Class B. Refer to National Semiconductor's "The Reliability Handbook".

Line length is a function of data rate (baud) and slew rate. The recommended safe operating area (line length vs baud rate is shown below for 24 AWG wire. It assumes that a differential line receiver is used which is referenced at the driver ground. Also, it assumes that the driver slew rate is between 0.1 to 0.3 times the reciprocal of the baud rate (minimum unit interval). Otherwise, line lengths greater than 50 feet are not recommended. The exception to line length is the 360 I/O coaxial interface. The coaxial provides improved grounding and eliminates crosstalk.



#### **UNBALANCED DRIVERS**

Propagation	Output	Output	Slew Rate	Party-Line	Open-Collector	Power	,	Circuits/	Device	e Number		Dane
Delay (ns)	Voltage (V)	Current (mA)	Control	Application	or Open Emitter	Supplies (V)	Standard	Package	Commercial 0°C to +70°C	Military -55°C to +125°C	Comment	Page No.
200	±6 or ±9	±6	I <sub>OS</sub> /C			±9 or ±15	RS-232	4	DS1488			1-7
60	±5	±10	IOS/C			±12	RS-232	2	DS75150	i		1-84
200	±2	±20	CEXT	Yes	TRI-STATE®	5 or ±5	RS-423	4	DS3691	DS1691A		1-37
200	±2	±20	CEXT	Yes	TRI-STATE	5 or ±5	MIL 188-114	4	DS3692	DS1692	±10V common-mode range	1-42
10	2.4 -	-100		Yes	Emitter	5	360 I/O	2	DS75121	DS55121	50 $\Omega$ coax. driver	1-66
10	2.4	-100		Yes	Emitter	5	360 I/O	2	DS75123		50 $\Omega$ coax, driver (IBM)	1-71
20	0.7	300		Yes	Emitter and Collector	5		2	D\$75450	 		3-51
18	0.7	300		Yes	Collector	5 .		2	DS75451	DS55451		3-51
26	0.7	300		Yes	Collector	5		2	DS75452	DS55452	,	3-51
18	0.7	300		Yes	Collector	5		2	DS75453	DS55453		3-51
27	0.7	300		Yes	Collector	5		2	DS75454	DS55454		3-51

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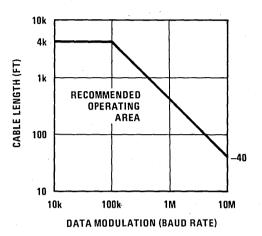
#### **UNBALANCED RECEIVERS**

Propagation	Threshold	Input	T	<b>.</b>	0	Power		0	Device	Number		Page
Delay (ns)	Sensitivity (V)	Range (V)	Hysteresis (mV)	Response Control	Strobed or TRI-STATE®	Supplies (V)	Standard	Circuits/ Package	Commercial 0°C to +70°C	Military -55°C to +125°C	Comments	No.
30	3 .	±25	250	CEXT		5	RS-232	4	DS1489			1-10
30	3	±25	1150	CEXT		5	RS-232	4	DS1489A		Preferential in applica- tions to DS1489	1-10
22	3	±25	800	CEXT		5 or 15	RS-232	4	DS75154			1-87
50	±0.2	±25	50	CEXT	Strobed	5	RS-423	.2	DS88LS120	DS78LS120	Fail-safe	1-116
50	±0.2	±25	50	C <sub>EXT</sub>	Strobed	5 to 15	RS-423	2	DS88C120	DS78C120	Fail-safe	1-109
17	±0.2	· ±7	100	İ	TRI-STATE	5	RS-423	4	DS26LS32C	DS26LS32M		1-15
23	±0.2	±7	100		TRI-STATE	5	RS-423	4	DS26LS32AC		Fail-safe	1-15
17	±0.5	±15	200	· 	TRI-STATE	5	RS-423	4	DS26LS33C	DS26LS33M		1-15
23	±0.5	±15	200		TRI-STATE	5	RS-423	4	DS26LS33AC		Fail-safe	1-15
25	±0.1	±15	100		TRI-STATE	5	RS-423	4	DS3486			1-18
20	0.8 to 2	7	600		Strobed	5	360 I/O	3	DS75122	DS55122	50Ω coax. receiver	1-68
20	0.8 to 2	7	400		Strobed	5	360 I/O	3	DS75124	DS55124	50Ω coax. receiver (IBM)	1-73
16	0.7 to 1.7	-2/7	ĺ			5	360 I/O	7	DS75125		IBM coax, receiver	1-76
16	0.7 to 1.7	-2/7	ĺ	}		5	360 I/O	7	DS75127		IBM coax, receiver	1-76
16	0.7 to 1.7	-2/7				5	360 I/O -	8	DS75128		IBM coax, receiver	1-80
16	0.7 to 1.7	-2/7		<u> </u>		5	360 I/O	8	DS75129		IBM coax. receiver	1-80

#### BALANCED (DIFFERENTIAL) TRANSMISSION LINE DRIVERS AND RECEIVERS

Balanced data transmission is applicable for long lines in the presence of high common-mode noise. Balanced circuits don't generate much noise and are also not susceptible to common-mode noise, and therefore work well in long lines when cabled with other signals.

Line length is a function of data rate (baud) and the combination of IR drop and skin effect. Refer to AN-108 and AN-22. The recommended safe operating area (line length vs baud rate) is shown for 24 AWG wire.



#### **BALANCED DRIVERS**

Propagation	V (VV	V (V)	Boute Line			Power		Circuits/	Devi	e Number		D
			Application	TRI-STATE®	Open-Collector	Power Supplies (V)	Standard	Dookson	1 Commercial	Military -55°C to +125°C	Comments	Page No.
10	0.5/40	1.8/-40		•		5		2	DS8830	DS7830		1-101
100	0.4/11	2.9/-57				5 or 15		2	MM88C30	MM78C30	CMOS comparator	CMOS
100	0.4/11	2.9/-57	}	1	j	5 or 15	,	2	MM88C29	MM78C29	Non-inverting MM88C30	CMOS
10	0.5/40	1.8/-40	Yes	TRISTATE	]	5		-2	DS8831	DS7831	· · · · · ·	1-104
10	0.5/40	1.8/-40	Yes	TRI-STATE	]	5	]	2	DS8832	DS7832	DS8831 without VCC clamp diode	1-104
13	0.4/40	2/-40	Yes	TRI-STATE	Optional	5	,	2	DS75113	DS55113		1-52
15	0.4/40	2/-40		ļ	Optional	5		2	DS75114	DS55114	·	1-57
200	-2/20	2/-20	Yes	TRI-STATE		5 or ±5	RS-422	2	DS3691	DS1691A		1-37
200	-2/20	2/-20	Yes	TRI-STATE	]	5 or ±5		2	DS3692	DS1692	±10V TRI-STATE common-mode	1-42
					j			· .			range	
15			Yes	TRI-STATE		5	RS-485	1	DS3695		RS-485 Transceiver	1-47
15	}		Yes	TRI-STATE		5	RS-485	1	DS3696		RS-485 Transceiver	1-47
15			Yes	TRI-STATE	·	5	RS-485	1	DS3697		RS-485 Transceiver	1-47
15			Yes	TRI-STATE		5	RS-485	1	DS3698		RS-485 Transceiver	1-47
12	0.5/40	2.5/-20	Yes	TRI-STATE		5	RS-422	4	DS26LS31C	DS26LS31M	, "I	1-12
15 ·	0.5/48	2/-50	Yes	TRI-STATE		5	RS-422	4	DS3487	DS3587		1-22

	<del></del>	Threshold	Common-Mode	<del> </del>		Γ	Power		<del></del> -	Davia	Number	<del></del>	<del>.</del>
- {	Propagation	Sensitivity	Range	Hysteresis	Response	Strobed or	Supplies	Standard	Circuits/	Commercial	Military	Comments	Page
-	Delay (ns)	(mV)	(V)	(mV)	Control	TRI-STATE®	(V)		Package	0°C to +70°C	-55°C to +125°C		No.
- 1	40	±1000	±15		Yes	Strobed	5		2	DS8820	DS7820		1-91
1	30	±1000	±15		Yes	Strobed	5		. 2	DS8820A	DS7820A		1-94
- 1	60	±200	±10	50	Yes	Strobed	5 to 15	RS-422	2	DS88C20	DS78C20	CMOS compatible	1-98
	60	±200	±10	50	Yes	Strobed	5 to 15	RS-422	2	DS88C120	DS78C120	Fail-safe, CMOS compatible	1-109
	50	±200	±10	50	Yes	Strobed	5	RS-422	2	DS88LS120	DS78LS120	Fail-safe	1-116
	20	±500	±15		Yes	Strobed	5		2	DS75115	DS55115		1-61
- 1	17	±200	±7	100		TRI-STATE	5	RS-422	4	DS26LS32C	DS26LS32M		1-15
	17	±200	±7	100		TRI-STATE	5	RS-422	4	DS26LS32AC		Fail-Safe	1-15
- 1	17	±500	±15	200		TRI-STATE	5	RS-422	4	DS26LS33C	DS26LS33M		1-15
- 1	17	±500	±15	200		TRI-STATE	5	RS-422	4	DS26LS33AC		Fail-Safe	1-15
	25	±200	±10	80		TRI-STATE	5	RS-422	4	DS3486			1-18
3	- 10	±25	±3			TRI-STATE	±5		4	DS365Q	DS1650		1-31
5	10	±25	±3			Strobed	±5		4	DS3652	DS1652		1-31
- {	22	±200	+12,7	70		TRI-STATE	5	RS-485	1	DS3695	1	RS-485 Transceiver	1-47
	22	±200	+12, -7	70		TRI-STATE	5	RS-485	1	DS3696		RS-485 Transceiver	1-47
1	22	±200	+12, -7	70		TRI-STATE	5	RS-485	1	DS3697	٠	RS-485 Transceiver	1-47
	22	±200	+12, -7	70		TRI-STATE	5	RS-485	1	DS3698		RS-485 Transceiver	1-47
	17	±25	±3			Strobed	±5		2	DS75107	DS55107		1-25
]	17	±10	±3			Strobed	±5		2	DS75207			1-25
	17	±25	±3			Strobed	±5		2	DS75108	DS55108		1-25
	17	±10	±3			Strobed	±5		2	DS75208			1-25
ļ	17	±25	±3			TRI-STATE	±5		2	DS3603	DS1603		1-25

Note. Voltage comparators (such as the LM710) have good threshold sensitivity and good common-mode range and, in turn, also make good line receivers. These comparators generally use 2 power supplies (±15V), which may not be available in some digital systems.

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# Transmission Line Drivers/Receivers

#### **DS1488 Quad Line Driver**

#### **General Description**

The DS1488 is a quad line driver which converts standard TTL input logic levels through one stage of inversion to output levels which meet EIA Standard No. RS-232C and CCITT Recommendation V. 24.

#### **Features**

■ Current limited output

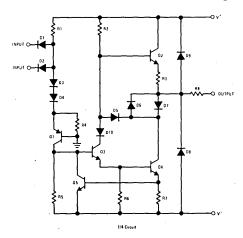
±10 mA typ

■ Power-off source impedance

 $300\Omega$  min

- Simple slew rate control with external capacitor
- Flexible operating supply range
- Inputs are TTL/LS compatible

#### **Schematic and Connection Diagrams**



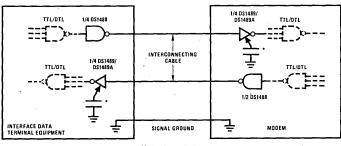
# 

TOP VIEW

Order Number DS1488J or DS1488N See NS Package J14A or N14A

#### **Typical Applications**

#### RS232C Data Transmission



\*Optional for noise filtering

#### Absolute Maximum Ratings (Note 1)

Supply Voltage

V<sup>+</sup> +15V

V<sup>-</sup> -15V

 $\begin{array}{ll} \mbox{Input Voltage (V_{IN})} & -15 \mbox{V} \leq \mbox{V}_{IN} \leq 7.0 \mbox{V} \\ \mbox{Output Voltage} & \pm 15 \mbox{V} \end{array}$ 

Operating Temperature Range 0°C to +75°C Storage Temperature Range -65°C to +150°C

Maximum Power Dissipation\* at 25°C

 Cavity Package
 1364 mW

 Molded Package
 1280 mW

 Lead Temperature (Soldering, 10 sec)
 300°C

\*Derate cavity package 9.1 mW/°C above 25°C; derate molded package 10.2 mW/°C above 25°C.

#### Electrical Characteristics: (Notes 2 and 3) $V_{CC}$ += 9V, $V_{CC}$ -= -9V unless otherwise specified

	PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
I <sub>IL</sub>	Logical "0" Input Current	V <sub>IN</sub> = 0V			-1.0	-1.3	mA
I <sub>IH</sub>	Logical "1" Input Current	V <sub>IN</sub> = +5.0V			0.005	10.0	μΑ
VoH	High Level Output Voltage	$R_L = 3.0 \text{ k}\Omega$	V <sup>+</sup> = 9.0V, V <sup>-</sup> = -9.0V	6.0	7.0		V
		$V_{IN} = 0.8V$	V <sup>+</sup> = 13.2V, V <sup>-</sup> = -13.2V	9.0	10.5		V
VoL	Low Level Output Voltage	$R_L = 3.0 \text{ k}\Omega$ ,	V <sup>+</sup> = 9.0V, V <sup>-</sup> = -9.0V		-6.8	-6.0	V
		V <sub>IN</sub> = 1.9V	V <sup>+</sup> = 13.2V, V <sup>-</sup> = -13.2V		-10.5	-9.0	V
l <sub>os</sub> +	High Level Output Short-Circuit Current	V <sub>OUT</sub> = 0V, V <sub>1</sub>	-6.0	-10.0	-12.0	mA	
l <sub>os</sub> -	Low Level Output . Short-Circuit Current	V <sub>OUT</sub> = 0V, V <sub>I</sub>	6.0	10.0	12.0	mA	
Rout	Output Resistance	V <sup>+</sup> = V <sup>-</sup> = 0V,	V <sub>OUT</sub> = ±2V	300			Ω
I <sub>cc</sub> +	Positive Supply Current		V <sup>+</sup> = 9.0V, V <sup>-</sup> = -9.0V		15.0	20.0	mA
	(Output Open)	V <sub>IN</sub> = 1.9V	V <sup>+</sup> = 12V, V <sup>-</sup> = -12V		19.0	25.0	mA
			V <sup>+</sup> = 15V, V <sup>-</sup> = -15V		25.0	34.0	mA
			$V^{+} = 9.0V, V^{-} = -9.0V$		4.5	6.0	mA
		$V_{IN} = 0.8V$	$V^{+} = 12V, V^{-} = -12V$		5.5	7.0	mA
			V <sup>+</sup> = 15V, V <sup>-</sup> = -15V		8.0	12.0	. mA
Icc-	Negative Supply Current		$V^{+} = 9.0V, V^{-} = -9.0V$		-13.0	-17.0	mA
	(Output Open)	$V_{1N} = 1.9V$	V <sup>+</sup> = 12V, V <sup>-</sup> = -12V		-18.0	-23.0	mA
			V <sup>+</sup> = 15V, V <sup>-</sup> = -15V		-25.0	-34.0	mA
			$V^{+} = 9.0V, V^{-} = -9.0V$		-0.001	-0.015	_mA
		V <sub>IN</sub> = 0.8V	$V^{+} = 12V, V^{-} = -12V$		÷0.001	-0.015	mA
			V <sup>+</sup> = 15V, V <sup>-</sup> = -15V		-0.01	-2.5	mA
$P_d$	Power Dissipation	V <sup>+</sup> = 9.0V, V <sup>-</sup>	$V^+ = 9.0V, V^- = -9.0V$			333	mW
	$V^{+} = 12V, V^{-} = -12V$				444	576	mW

#### Switching Characteristics (V<sub>CC</sub> = 9V, V<sub>EE</sub> = -9V, T<sub>A</sub> = 25°C)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd1</sub>	Propagation Delay to a Logical "1"	$R_L = 3.0 \text{ k}\Omega, C_L = 15 \text{ pF}, T_A = 25^{\circ}\text{C}$	}	230	350	ns
t <sub>pd0</sub>	Propagation Delay to a Logical "0"	$R_L = 3.0 \text{ k}\Omega, C_L = 15 \text{ pF}, T_A = 25^{\circ}\text{C}$	ļ	70	175	ns
t <sub>r</sub> .	Rise Time	$R_L = 3.0 \text{ k}\Omega, C_L = 15 \text{ pF}, T_A = 25^{\circ}\text{C}$		75	100	ns
t <sub>f</sub>	Fall Time	$R_L = 3.0 \text{ k}\Omega, C_L = 15 \text{ pF}, T_A = 25^{\circ}\text{C}$		40	75	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $9^{\circ}$ C to +75° C temperature range for the DS1488.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

#### **Applications**

By connecting a capacitor to each driver output the slew rate can be controlled utilizing the output current limiting characteristics of the DS1488. For a set slew rate the appropriate capacitor value may be calculated using the following relationship

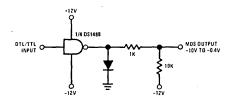
$$C = I_{SC} (\triangle T / \triangle V)$$

where C is the required capacitor,  $I_{SC}$  is the short circuit current value, and  $\Delta V/\Delta T$  is the slew rate.

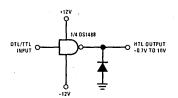
RS232C specifies that the output slew rate must not exceed 30V per microsecond. Using the worst case output short circuit current of 12 mA in the above equation, calculations result in a required capacitor of 400 pF connected to each output.

#### Typical Applications (Continued)

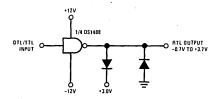
DTL/TTL-to-MOS Translator



#### DTL/TTL-to-HTL Translator

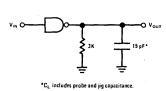


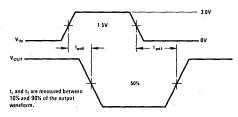
DTL/TTL-to-RTL Translator



#### **AC Load Circuit**

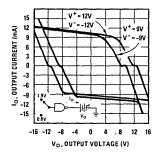
#### **Switching Time Waveforms**





#### **Typical Performance Characteristics**

#### **Output Voltage and Current-Limiting Characteristics**





# Transmission Line Drivers/Receivers

#### DS1489/DS1489A Quad Line Receiver

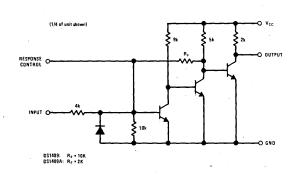
#### **General Description**

The DS1489/DS1489A are quad line receivers designed to interface data terminal equipment with data communications equipment. They are constructed on a single monolithic silicon chip. These devices satisfy the specifications of EIA standard No. RS232C. The DS1489/DS1489A meet and exceed the specifications of MC1489/MC1489A and are pin-for-pin replacements.

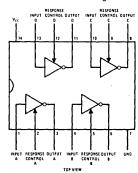
#### **Features**

- Four totally separate receivers per package
- Programmable threshold
- Built-in input threshold hysteresis
- "Fail safe" operating mode
- Inputs withstand ±30V

#### **Schematic and Connection Diagrams**

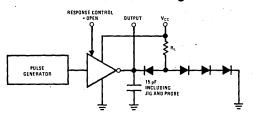


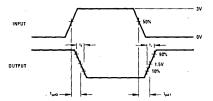
#### Dual-In-Line Package



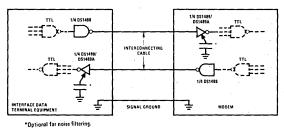
Order Number DS1489J, DS1489AJ, DS1489N or DS1489AN See NS Package J14A or N14A

#### **AC Test Circuit and Voltage Waveforms**

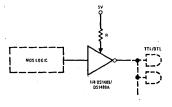




#### **Typical Applications**



RS232C Data Transmission



MOS to TTL/LS Translator

#### Absolute Maximum Ratings (Note 1)

The following apply for T<sub>A</sub> = 25°C unless otherwise specified.

Power Supply Voltage 10V
Input Voltage Range ±30V
Output Load Current 20 mA
Power Dissipation (Note 2) 1W
Operating Temperature Range 0°C to +75°C
Storage Temperature Range 65°C to +150°C
Maximum Power Dissipation\* at 25°C
Cavity Package 1308 mW

Molded Package

#### Electrical Characteristics (Notes 2, 3 and 4)

DS1489/DS1489A: The following apply for  $V_{CC}$  = 5.0V ±1%,  $0^{\circ}C \le T_{A} \le +75^{\circ}C$  unless otherwise specified.

1207 mW

	PARAMETER	CC	ONDITIONS		MIN	TYP	MAX	UNITS
V <sub>TH</sub>	Input High Threshold Voltage		DS1489	T <sub>A</sub> = 25°C	1.0	1.25	1.5	V
		$V_{OUT} \leq 0.45V$	D3 1409		0.9		1.6	V
£.		I <sub>OUT</sub> = 10 mA	DS1489A	$T_A = 25^{\circ}C$	1.75	2.00	2.25	V
			אלפטיונע		1.55		2.40	V
V <sub>TL</sub>	Input Low Threshold Voltage	$V_{OUT} \ge 2.5V$		T <sub>A</sub> = 25°C	0.75	1.00	1.25	V
		$I_{OUT} = -0.5 \text{ mA}$	0.65		1.35	V		
I <sub>IN</sub>	Input Current	V <sub>IN</sub> = +25V	+3.6	+5.6	+8.3	mA		
		V <sub>IN</sub> = -25V	−3.6	-5.6	-8.3	mA		
		V <sub>IN</sub> = +3V	+0.43	+0.53		mA		
		$V_{IN} = -3V$	-0.43	-0.53		mA.		
V <sub>OH</sub>	Output High Voltage	I <sub>OUT</sub> = -0.5 mA	V <sub>IN</sub> = 0.75	2.6	3.8	5.0	V	
,		1007 - 0.5111A	Input = Op	en .	2.6	3.8	5.0	, V
VoL	Output Low Voltage	V <sub>IN</sub> = 3.0V, I <sub>OUT</sub>	V <sub>IN</sub> = 3.0V, I <sub>OUT</sub> = 10 mA				0.45	V
I <sub>sc</sub>	Output Short Circuit Current	V <sub>IN</sub> = 0.75V				3.0		mA
Icc	Supply Current	V <sub>IN</sub> = 5.0V				14	26	mA
P <sub>d</sub>	Power Dissipation	V <sub>IN</sub> = 5.0V				70	130	mW

#### Switching Characteristics (V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS	
t <sub>pd1</sub>	Input to Output "High" Propagation Delay	R <sub>L</sub> = 3.9k, (Figure 1) (ac Test Circuit)		28	85	ns	
t <sub>pd0</sub>	Input to Output "Low" Propagation Delay	R <sub>L</sub> = 390Ω, (Figure 1) (ac Test Circuit)		20	50	ns	
t <sub>r</sub>	Output Rise Time	R <sub>L</sub> = 3.9k, (Figure 1) (ac Test Circuit)		110	175	ns	
t <sub>f</sub>	Output Fall Time	$R_L = 390\Omega$ , (Figure 1) (ac Test Circuit)		9	20	ns	

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2. Unless otherwise specified min/max limits apply across the 0°C to +75°C temperature range for the DS1489 and DS1489A.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

<sup>\*</sup>Derate cavity package 8.7 mW/°C above 25°C; derate molded package 9.7 mW/°C above 25°C.

Note 4: These specifications apply for response control pin = open.

# National To Semiconductor DS26LS31C/DS26LS31M Quad High Speed Differential Line Driver

# General Description

The DS26LS31 is a quad differential line driver designed for digital data transmission over balanced lines. The DS26LS31 meets all the requirements of EIA Standard

RS-422 and Federal Standard 1020. It is designed to provide unipolar differential drive to twisted-pair or parallel-wire transmission lines.

The circuit provides an enable and disable function common to all four drivers. The DS26LS31 features TRI-STATE® outputs and logically ANDed complementary outputs. The inputs are all LS compatible and are all one unit load.

The DS26LS31 features a power up/down protection circuit which TRI-STATEs the outputs during power up or down preventing erroneous glitches on the transmission lines.

# Features

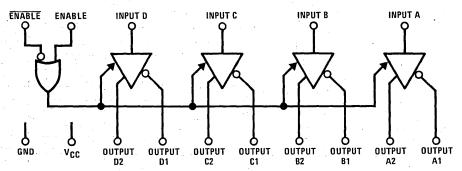
- Output skew 2.0 ns typical
- Input to output delay 10 ns
- Operation from single 5V supply
- 16-pin hermetic and molded DIP package
- Outputs won't load line when VCC = 0
- Four line drivers in one package for maximum package density

**Transmission Line** 

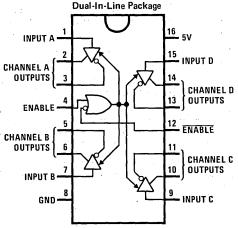
**Drivers/Receivers** 

- Output short-circuit protection
- Complementary outputs
- Meets the requirements of EIA Standard RS-422
- Pin compatible with AM26LS31
- Available in military and commercial temperature range
- Glitch free power up/down

#### Logic Diagram



#### **Connection Diagram**



TOP VIEW
Order Number DS26LS31CJ, DS26LS31CN or
DS26LS31MJ
See NS Package J16A or N16A

		MIM	MAX	UNITS
Supply Voltage 7V	Supply Voltage, V <sub>CC</sub>			
Input Voltage 7V	DS26LS31M	4.5	5.5	V
Output Voltage 5V	DS26LS31	4.75	5.25	V
Output Voltage (Power OFF) -0.25V to 6V	Temperature, T <sub>A</sub>			
Maximum Power Dissipation* at 25°C	DS26LS31M	55	+125	°C
Cavity Package 1509 mW	DS26LS31	0	+70	°C
Molded Package 1476 mW				

# Electrical Characteristics (Notes 2, 3 and 4)

	PARAMETER	CON	IDITIONS	MiN	TYP	MAX	UNITS
Voн	Output High Voltage	Іон = -	20 mA	2.5			V
VOL	Output Low Voltage	IOL = 20	) mA			0.5	V
VIH	Input High Voltage			2.0			V
VIL	Input Low Voltage					0.8	V
IIL	Input Low Current	VIN = 0.	4V		-40	-200	μΑ
ЧH	Input High Current	V <sub>IN</sub> = 2.	7V			20	μΑ
IJ	Input Reverse Current	VIN = 7	v			0.1	mA
10	TRI-STATE Output Current		V <sub>O</sub> = 2.5V			20	μΑ
	•		V <sub>O</sub> = 0.5V			-20	μΑ
VCL	Input Clamp Voltage	I <sub>IN</sub> = -1	8 mA			-1.5	٧
Isc	Output Short-Circuit Current			-30		-150	mA
lcc	Power Supply Current	All Outp	uts Disabled		35	60	mA

# Switching Characteristics VCC = 5V, TA = 25°C

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
tPLH	Input to Output	CL = 30 pF		10	15	ns
tPHL	Input to Output	CL = 30 pF		10	15	ns
Skew	Output to Output	CL = 30 pF		2.0	6.0	ns
tLZ	Enable to Output	CL = 10 pF, S2 Open		15	35	ns
tHZ	Enable to Output	CL = 10 pF, S1 Open		15	25	ns
<sup>t</sup> ZL	Enable to Output	CL = 30 pF, S2 Open		20	30	ns
tZH	Enable to Output	CL = 30 pF, S1 Open		20	30	ns

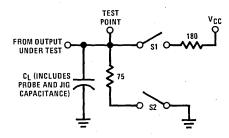
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the .-55°C to +125°C temperature range for the DS26LS31M and across the  $0^{\circ}$ C to +70°C range for the DS26LS31. All typicals are given for V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C.

Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise specified.

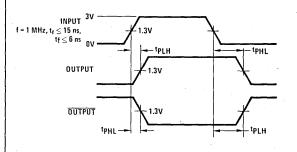
Note 4: Only one output at a time should be shorted.

# **AC Test Circuit and Switching Time Waveforms**



Note. S1 and S2 of load circuit are closed except where shown.

FIGURE 1. AC Test Circuit



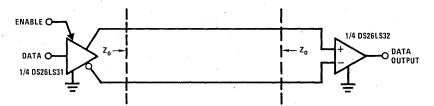
ENABLE INPUT 3V ENABLE DISABLE  $f = 1 \text{ MHz}, t_r \le 15 \text{ ns}, t_f \le 6 \text{ ns}$  OV  $t_f \le 6 \text{ ns}$  OUTPUT S2 OPEN  $v_{OH}$  OUTPUT S1 OPEN  $v_{OH}$  1.3V  $v_{PHZ}$   $v_{PHZ}$   $v_{PHZ}$   $v_{PHZ}$ 

FIGURE 2. Propagation Delays

FIGURE 3. Enable and Disable Times

# **Typical Applications**

Two-Wire Balanced System, RS-422





# Transmission Line Drivers/Receivers

# DS26LS32C/DS26LS32M, DS26LS32AC, DS26LS33C/DS26LS33M, DS26LS33AC Quad Differential Line Receivers

# **General Description**

The DS26LS32 and DS26LS32A are quad differential line receivers designed to meet the RS-422, RS-423 and Federal Standards 1020 and 1030 for balanced and unbalanced digital data transmission.

The DS26LS32 and DS26LS32A have an input sensitivity of 200 mV over the input voltage range of  $\pm$  7V and the DS26LS33 and DS26LS33A have an input sensitivity of 500 mV over the input voltage range of  $\pm$  15V.

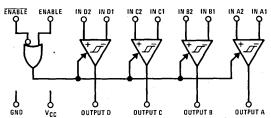
Both the DS26LS32A and DS26LS33A differ in function from the popular DS26LS32 and DS26LS33 in that input fail-safe circuitry is provided for each receiver, which causes the outputs to go to a logic "1" state when the inputs are open.

Each version provides an enable and disable function common to all four receivers and features TRI-STATE® outputs with 8 mA sink capability. Constructed using low power Schottky processing, these devices are available over the full military and commercial operating temperature ranges.

### **Features**

- High differential or common-mode input voltage ranges of ± 7V on the DS26LS32 and DS26LS32A and ± 15V on the DS26LS33 and DS26LS33A
- ±0.2V sensitivity over the input voltage range on the DS26LS32 and DS26LS32A, ±0.5V sensitivity on the DS26LS33 and DS26LS33A
- Input fail-safe circuitry on the DS26LS32A and DS26LS33A
- DS26LS32 and DS26LS32A meet all requirements of RS-422 and RS-423
- 6k minimum input impedance
- 100 mV input hysteresis on the DS26LS32 and DS26LS32A, 200 mV on the DS26LS33 and DS26LS33A
- Operation from a single 5V supply
- TRI-STATE drive, with choice of complementary output enables for receiving directly onto a data bus
- Pin replacement for Advanced Micro Devices AM26LS32

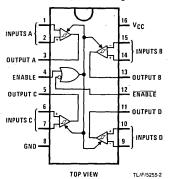
# **Logic Diagram**



TL/F/5255-1

# **Connection Diagram**

#### Dual-In-Line Package



TRI-STATE® is a registered trademark of National Semiconductor Corp.

# **Truth Table**

ENABLE	ENABLE	Input	Output
0 1		Х	Hi-Z
	ee	V <sub>ID</sub> ≥ V <sub>TH</sub> (Max)	1
1 -		V <sub>ID</sub> ≤ V <sub>TH</sub> (Min)	0
Note Below		Open	1*

Hi-Z = TRI-STATE

\*DS26LS32A and DS26LS33A only

Note: Input conditions may be any combination not defined for ENABLE and ENABLE.

Order Number DS26LS32MJ, DS26LS32CJ, DS26LS32CN, DS26LS32ACJ, DS26LS32ACN, DS26LS33MJ, DS26LS33CJ, DS26LS33CN, DS26LS33ACJ or DS26LS33ACN See NS Package J16A or N16A 10.9 mW/°C above 25°C.

Absolute Maximum Ratings (Note 1)		Operating Conditions	<b>S</b> .		
			Min	Max	Units
Supply Voltage	7V	Supply Voltage (V <sub>CC</sub> )			
Common-Mode Range	± 25V	DS26LS32M, DS26LS33M	4.5	5.5	٧
Differential Input Voltage	± 25V	(MIL)			
Enable Voltage	7V	DS26LS32C, DS26LS33C	4.75	5.25	٧
Output Sink Current	50 mA	DS26LS32AC, DS26LS33AC (COML)			
Maximum Power Dissipation* at 2	5°C	Temperature (T <sub>A</sub> )			
Cavity Package	1433 mW	DS26LS32M, DS26LS33M	- 55	+ 125	°C
Molded Package	1362 mW	(MIL)	-		•
Storage Temperature Range	-65°C to +165°C	DS26LS32C, DS26LS33C	0	+ 70	°C
Lead Temperature (Soldering, 10 se	conds) 300°C	DS26LS32AC, DS26LS33AC (COML)			
*Derate cavity package 9.6 mW/°C above 25	6°C; derate molded package	(002)			

Electrical Characteristics over the operating temperature range unless otherwise specified (Notes 2, 3 and 4)

	Parameter		Condit	ions	Min	Тур	Max	Units
V <sub>TH</sub>	Differential Input	V <sub>OUT</sub> = V <sub>OH</sub>	DS26LS32, DS2	6LS32A, -7V≤V <sub>CM</sub> ≤+7V	-0.2	± 0.07	0.2	٧
	Voltage	or V <sub>OL</sub>	DS26LS33, DS2	6LS33A, -15V≤V <sub>CM</sub> ≤ +15V	-0.5	± 0.14	0.5	٧
R <sub>IN</sub>	Input Resistance	- 15V≤V <sub>CM</sub> ≤	≤ + 15V (One Input	AC GND)	6.0	8.5		kΩ
I <sub>IN</sub>	Input Current (Under	V <sub>IN</sub> = 15V, Oth	er Input – 15V≤V	<sub>N</sub> ≤ + 15V			2.3	mA
	Test)	$V_{1N} = -15V, C$	Other Input – 15V≤	V <sub>IN</sub> ≤ + 15V			- 2.8	mA
V <sub>OH</sub>	Output High Voltage	V <sub>CC</sub> = Min, ΔV	/ <sub>IN</sub> = 1V,	Commercial	2.7	4.2		V
		$V_{\overline{\text{ENABLE}}} = 0.8$	$V, I_{OH} = -440 \mu A$	Military	2.5	4.2		٧
VOL	Output.Low Voltage	$V_{CC} = Min, \Delta V$	$t_{\rm IN} = -1 \text{V},$	I <sub>OL</sub> = 4 mA			0.4	V
		$V_{\overline{\text{ENABLE}}} = 0.8$	<b>V</b>	I <sub>OL</sub> = 8 mA			0.45	V
VIL	Enable Low Voltage						0.8	٧
V <sub>IH</sub>	Enable High Voltage							٧
VI	Enable Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub>	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18 mA				- 1.5	٧
I <sub>O</sub>	OFF-State (High	V <sub>CC</sub> = Max		V <sub>O</sub> = 2.4V			20	μА
	Impedance) Output Current			V <sub>O</sub> = 0.4V			- 20	μΑ
I <sub>IL</sub>	Enable Low Current	$V_{IN} = 0.4V$					- 0.36	mA
I <sub>IH</sub>	Enable High Current	$V_{1N} = 2.7V$					20	μА
I <sub>sc</sub>	Output Short-Circuit Current	$V_0 = 0V$ , $V_{CC} =$	= Max, ΔV <sub>IN</sub> = 1V		- 15		- 85	mA
Icc	Power Supply	V <sub>CC</sub> = Max, A	II V <sub>IN</sub> = GND,	DS26LS32, DS26LS32A		52	70	mA
	Current	Outputs Disa	bled	DS26LS33, DS26LS33A		57	80	mA
11	Input High Current	V <sub>IN</sub> = 5.5V					100	μΑ
V <sub>HYST</sub>	Input Hysteresis	$T_A = 25$ °C, $V_C$	<sub>C</sub> = 5V,	DS26LS32, DS26LS32A		100		mV
		$V_{CM} = 0V$		DS26LS33, DS26LS33A		200		mV

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max or min are so classified on absolute value basis.

Note 3: All typical values are  $V_{CC} = 5V$ ,  $T_A = 25$ °C.

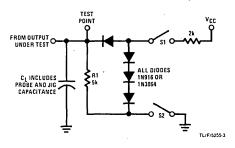
Note 4: Only one output at a time should be shorted.

# Switching Characteristics V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C

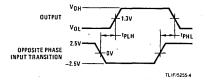
	Parameter	Conditions DS26LS32/I		_S32/DS2	32/DS26LS33 DS26LS32A/DS26LS33A			Unite	
	ratailletet	Conditions	Min	Тур	Max	Min	Тур	Max	Units
t <sub>PLH</sub>	Input to Output	$C_1 = 15 pF$		17	25		23	35	ns
t <sub>PHL</sub>	input to Output	O[ = 15 pr		17	25		23	35	ns
t <sub>LZ</sub>	ENABLE to Output	C <sub>1</sub> = 5 pF		20	30		15	22	ns
t <sub>HZ</sub>	ENABLE to Output	OL=3 br		15	22		20	25	ns
tzL	ENABLE to Output	C <sub>1</sub> = 15 pF		15	22		14	22	ns
t <sub>ZH</sub>	ENABLE to Output	OL = 15 pr		15	22		15	22	ns

# **AC Test Circuit and Switching Time Waveforms**

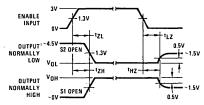
#### Load Test Circuit for TRI-STATE Outputs



#### Propagation Delay (Notes 1 and 3)



Enable and Disable Times (Notes 2 and 3)



TL/F/5255-5

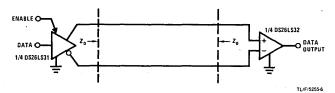
Note 1: Diagram shown for ENABLE low.

Note 2: S1 and S2 of load circuit are closed except where shown.

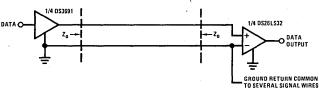
Note 3: Pulse generator for all pulses: Rate  $\leq$  1.0 MHz;  $Z_O = 50\Omega$ ;  $t_f \leq$  15 ns;  $t_f \leq$  6.0 ns.

# **Typical Applications**

#### Two-Wire Balanced Systems, RS-422



#### Single Wire with Common Ground Unbalanced Systems, RS-423



TL/F/5255-7

# National Semiconductor

# Transmission Line Drivers/Receivers

# DS3486 Quad RS-422, RS-423 Line Receiver

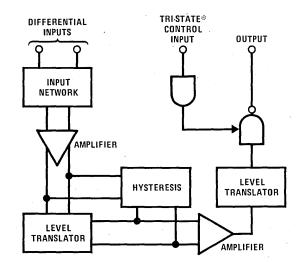
### **General Description**

National's quad RS-422, RS-423 receiver features four independent receiver chains which comply with EIA Standards for the electrical characteristics of balanced/unbalanced voltage digital interface circuits. Receiver outputs are 74LS compatible, TRI-STATE® structures which are forced to a high impedance state when the appropriate output control pin reaches a logic zero condition. A PNP device buffers each output control pin to assure minimum loading for either logic one or logic zero inputs. In addition, each receiver chain has internal hysteresis circuitry to improve noise margin and discourage output instability for slowly changing input waveforms.

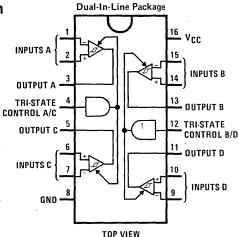
#### **Features**

- Four independent receiver chains
- TRI-STATE outputs
- High impedance output control inputs (PIA compatible)
- Internal hysteresis 140 mV (typ)
- Fast propagation times 18 ns (typ)
- TTL compatible
- Single 5V supply voltage
- Pin compatible and interchangeable with MC3486

## **Block Diagram**



# **Connection Diagram**



Order Number DS3486J or DS3486N

ower Supply Voltage, VCC	8 V
nput Common-Mode Voltage, VICM	±25 V
nput Differential Voltage, V <sub>ID</sub>	±25 V
RI-STATE Control Input Voltage, V	8 V
Output Sink Current, IO	50 mA
torage Temperature, TSTG	–65°C to +150°C
laximum Power Dissipation* at 25°C	
Cavity Package	1433 mW
Molded Package	1362 mW
Output Sink Current, IO torage Temperature, T <sub>STG</sub> Naximum Power Dissipation* at 25°C Cavity Package	50 r 65°C to +150 1433 n

Absolute Maximum Ratings (Note 1)

**Operating Conditions** 

	101114	1111777	0.4.1.
Power Supply Voltage, V <sub>CC</sub>	4.75	5.25	· <b>V</b>
Operating Temperature, TA	0	70 .	°C
Input Common-Mode Voltage	-7.0	7.0	V
Range, VICE			

#### **Electrical Characteristics**

(Unless otherwise noted, minimum and maximum limits apply over recommended temperature and power supply voltage ranges. Typical values are for  $T_A = 25^{\circ}$ C,  $V_{CC} = 5$ V and  $V_{IC} = 0$ V. See Note 2.)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
VIH	Input Voltage — High Logic State (TRI-STATE Control)		2.0			V
VIL	Input Voltage — Low Logic State (TRI-STATE Control)				0.8	٧
VTH(D)	Differential Input Threshold Voltage	$-7V \le V_{IC} \le 7V$ , V <sub>IH</sub> TRI-STATE = 2V $I_{O} = 0.4 \text{ mA}$ , $V_{OH} \ge 2.7V$ $I_{O} = 8 \text{ mA}$ , $V_{OI} \ge 0.5V$		0.070	0.2 -0.2	V
I <sub>IB</sub> (D)	Input Bias Current	V <sub>CC</sub> = 0V or 5.25V, Other Inputs at 0V V <sub>I</sub> = -10V V <sub>I</sub> = -3V V <sub>I</sub> = 3V			-3.25 -1.50	mA mA
	·	V <sub>I</sub> = 10V			1.50 3.25	mA mA
	Input Balance	$-7V \le V_{IC} \le 7V$ , $V_{IH(3C)} = 2V$ , $(Note 4)$ $I_{O} = 0.4 \text{ mA}$ , $V_{ID} = 0.4V$ $I_{O} = 8 \text{ mA}$ , $V_{ID} = -0.4V$	2.7		0.5	V
loz	Output TRI-STATE Leakage Current	$V_{I(D)} = 3V, V_{IL} = 0.8V, V_{OL} = 0.5V$ $V_{I(D)} = -3V, V_{IL} = 0.8V, V_{OH} = 2.7V$			-40 40	μA μA
los	Output Short-Circuit Current	$V_{I(D)}$ = 3V, $V_{IH}$ TRI-STATE = 2V, $V_{O} \approx 0$ , (Note 3)	-15		-100	mA
IJĹ	Input Current — Low Logic State (TRI-STATE Control)	V <sub>IL</sub> = 0.5V			-100	μΑ
ΊΗ	Input Current — High Logic State (TRI-STATE Control)	V <sub>IH</sub> = 2.7V V <sub>IL</sub> = 5.25V	-		20 100	μA μA
VIC	Input Clamp Diode Voltage (TRI-STATE Control)	IIN = -10 mA			-1.5	V
Icc	Power Supply Current	All Inputs VIL = 0V			85	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: All currents into device pins are shown as positive, out of device pins are negative. All voltages referenced to ground unless otherwise noted

Note 3: Only one output at a time should be shorted.

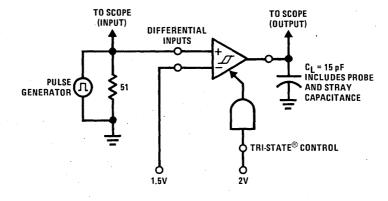
Note 4: Refer to EIA RS-422/3 for exact conditions.

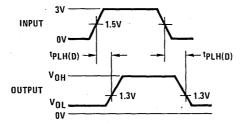
<sup>\*</sup>Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.2 mW/°C above 25°C.

# Switching Characteristics (Unless otherwise noted, V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C.)

PARAMETER			TYP	MAX	UNITS
	Propagation Delay Time — Differential Inputs to Output				
tPHL(D)	Output High to Low		19	35	ns
tPLH(D)	Output Low to High		19	30	ns '
	Propagation Delay Time - TRI-STATE Control to				
	Output			ł	}
tPLZ	Output Low to TRI-STATE		23	35	ı ns
tPHZ	Output High to TRI-STATE		25	35	ns
tPZH	Output TRI-STATE to High		18	30	ns
tPZL	Output TRI-STATE to Low		20	30	ns

# **AC Test Circuits and Switching Time Waveforms**

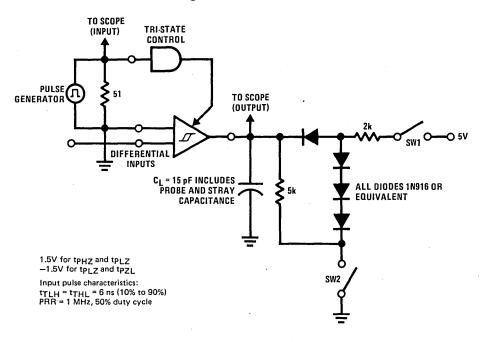




Input pulse characteristics: t<sub>TLH</sub> = t<sub>THL</sub> = 6 ns (10% to 90%) PRR = 1 MHz, 50% duty cycle

FIGURE 1. Propagation Delay Differential Input to Output

# AC Test Circuits and Switching Time Waveforms (Continued)



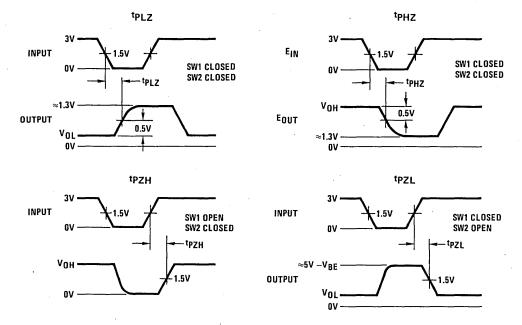


FIGURE 2. Propagation Delay TRI-STATE Control Input to Output



# Transmission Line Drivers/Receivers

# DS3587/DS3487 Quad TRI-STATE® Line Driver

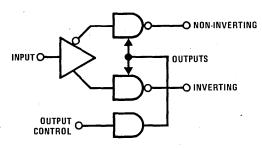
## **General Description**

National's quad RS-422 driver features four independent driver chains which comply with EIA Standards for the electrical characteristics of balanced voltage digital interface circuits. The outputs are TRI-STATE® structures which are forced to a high impedance state when the appropriate output control pin reaches a logic zero condition. All input pins are PNP buffered to minimize input loading for either logic one or logic zero inputs. In addition, internal circuitry assures a high impedance output state during the transition between power up and power down.

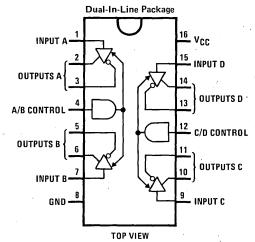
### **Features**

- Four independent driver chains
- **■** TRI-STATE outputs
- PNP high impedance inputs (PIA compatible)
- Power up/down protection
- Fast propagation times (typ 10 ns)
- TTL compatible
- Single 5V supply voltage
- Output rise and fall times less than 20 ns (typ 10 ns)
- Pin compatible with MC3487
- Output skew 2 ns typ

### **Block Diagram**



### **Connection Diagram**



Order Number DS3587J, DS3487J or DS3487N See NS Package J16A or N16A

### **Truth Table**

INPUT	CONTROL INPUT	NON-INVERTER OUTPUT	INVERTER OUTPUT
Н	н	. н	L
L	н	L	н
X	L	Z	Z

L = Low logic state

H = High logic state

X = Irrelevant

Z = TRI-STATE (high impedance)

nput Voltage  torage Temperature  _ead Temperature (Soldering, 10 seconds)  Maximum Power Dissipation* at 25° C  Cavity Package  150	Operating Condi				
			MIN	MAX	UNITS
Supply Voltage	8V	Supply Voltage (VCC)			
Input Voltage	5.5V	D\$3587	4.5	5.5	V
Storage Temperature	-65°C to +150°C	DS3487	4.75	5.25	V
Lead Temperature (Soldering, 10 seconds)	300°C	Temperature (T <sub>A</sub> )			
Maximum Power Dissipation* at 25°C		DS3587	-55	+125	°C
Cavity Package	1509 mW	DS3487	0	70	· °C
Molded Package	1476 mW				
*Derate cavity package 10.1 mW/°C above	e 25° C; derate molded				

### Electrical Characteristics (Notes 2, 3, 4 and 5)

package 11.9 mW/°C above 25°C.

	PARAMETER	CONDI	TIONS	MIN	TYP	MAX	UNITS
VIL	Input Low Voltage					0.8	V
VIH	Input High Voltage			2.0			V
li L	Input Low Current	V <sub>IL</sub> = 0.5	V			-200	μΑ
IIH	Input High Current		V <sub>1H</sub> = 2.7V			50	μА
	<u> </u>	İ	V <sub>1H</sub> = 5.5V			100	μΑ
VCL	Input Clamp Voltage	I <sub>CL</sub> = -18	3 mA			-1.5	>
VoL	Output Low Voltage	I <sub>OL</sub> = 48	mA			0.5	V
Voн	Output High Voltage	I <sub>OH</sub> = -2	0 mA	2.5			V
los	Output Short-Circuit Current			-40		-140	mA
loz	Output Leakage Current (TRI-STATE)		V <sub>O</sub> = 0.5V			-100	μΑ
			V <sub>O</sub> = 5.5V			100	μΑ
IOFF	Output Leakage Current Power OFF	V <sub>CC</sub> = 0	V <sub>O</sub> = 6V			100	μΑ
		VCC - 0	$V_0 = -0.25V$			-100	μΑ
$ V_{OS} - \overline{V}_{OS} $	Difference in Output Offset Voltage					0.4	V
VT	Differential Output Voltage			2.0	[		V
$ V_T  -  \overline{V}_T $	Difference in Differential Output Voltage					0.4	V
Icc	Power Supply Current		Active		50	80	mA
	•	}	TRI-STATE		35	60	mA

# **Switching Characteristics** $V_{CC} = 5V, T_A = 25^{\circ}C$

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
tPHL	Input to Output			10	15	ns
tPLH.	Input to Output			10	15	ns
<sup>t</sup> THL	Differential Fall Time			10	15	ns
<sup>t</sup> TLH	Differential Rise Time			10	15	ns
tPHZ	Enable to Output	$R_L = 200\Omega$ , $C_L = 50 pF$		17	25	ns
tPLZ .	Enable to Output	$R_L = 200\Omega$ , $C_L = 50 pF$		15	25	· ns
tPZH	Enable to Output	R <sub>L</sub> = ∞, C <sub>L</sub> = 50 pF, S1 Open		11	25	ns
tPZL	Enable to Output	R <sub>L</sub> = 200Ω, C <sub>L</sub> = 50 pF, S2 Open		15	25	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS3487. All typicals are given for  $V_{CC} = 5V$  and  $T_{A} = 25^{\circ}$ C.

Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise specified.

Note 4: Only one output at a time should be shorted.

Note 5: Symbols and definitions correspond to EIA RS-422, where applicable.

# **AC Test Circuits and Switching Time Waveforms**

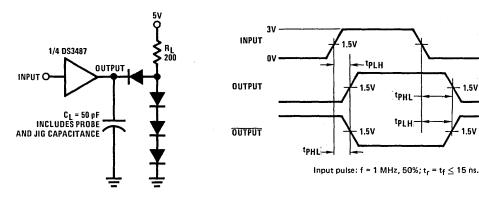


FIGURE 1. Propagation Delays

<sup>t</sup>PLH

**TPHL** 

tPLH:

1.5V

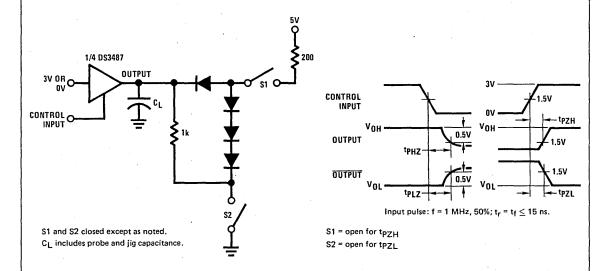


FIGURE 2. TRI-STATE Enable and Disable Delays

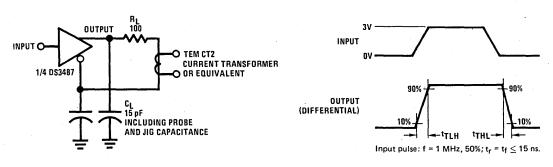


FIGURE 3. Differential Rise and Fall Times



# Transmission Line Drivers/Receivers

# DS1603/DS3603, DS55107/DS75107, DS55108/DS75108, DS75207, DS75208 Dual Line Receivers

### **General Description**

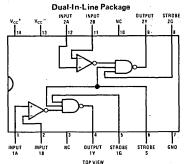
The eight products described herein are TTL compatible dual high speed circuits intended for sensing in a broad range of system applications. While the primary usage will be for line receivers or MOS sensing, any of the products may effectively be used as voltage comparators, level translators, window detectors, transducer preamplifiers. and in other sensing applications. As digital line receivers the products are applicable with the SN55109/SN75109 and SN55110/SN75110 companion drivers, or may be used in other balanced or unbalanced party-line data transmission systems. The improved input sensitivity and delay specifications of the DS75207 and DS75208 make them ideal for sensing high performance MOS memories as well as high sensitivity line receivers and voltage comparators. TRI-STATE® products enhance bused organizations.

Input protection diodes are incorporated in series with the collectors of the differential input stage. These diodes are useful in certain applications that have multiple  $V_{CC}^+$  supplies or  $V_{CC}^+$  supplies that are turned off.

### **Features**

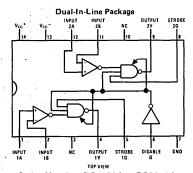
- Diode protected input stage for power "OFF" condition
- 17 ns typ high speed
- TTL compatible
- ±10 mV or ±25 mV input sensitivity
- ±3V input common-mode range
- High input impedance with normal  $V_{CC}$ , or  $V_{CC} = 0V$
- Strobes for channel selection
- TRI-STATE outputs for high speed buses
- Dual circuits
- Sensitivity gntd, over full common-mode range
- Logic input clamp diodes—meets both "A" and "B" version specifications
- ±5V standard supply voltages

# **Connection Diagrams**



Order Number DS55107J, DS75107J, DS55108J, DS75108J, DS75207J or DS75208J See NS Package J14A

Order Number DS75107N, DS75108N, DS75207N or DS75208N See NS Package N14A



Order Number DS1603J or DS3603J See NS Package J14A

> Order Number DS3603N See NS Package N14A

### **Product Selection Guide**

TEMPERATURE→ PACKAGE→	-55°C ≤ T <sub>A</sub> ≤ +125°C CAVITY DIP	$0^{\circ}\text{C} \leq \text{T}_{\text{A}} \leq +70^{\circ}\text{C}$ CAVITY OR MOLDED DIP			
INPUT SENSITIVITY-	±25 mV	±25 mV	±10 mV		
, TTL Active Pull-up TTL Open Collector TTL TRI-STATE	DS55107 DS55108 DS1603	DS75107 DS75108 DS3603	DS75207 DS75208 DS3604		

# Absolute Maximum Ratings (Notes 1, 2 and 3)

-65°C to +150°C

Supply Voltage, VCC+	7V	Maximum Power Dissipation* at 25°C	
Supply Voltage, VCC	-7V	Cavity Package	1308 mW
Differential Input Voltage	±6V	Molded Package	1207 mW
Common Mode Input Voltage	±5V	Lead Temperature (Soldering, 10 sec)	300°C
Strobe Input Voltage	5.5∨		
Storage Temperature Range	-65°C to +150°C	*Derate cavity package 8.7 mW/°C above	

molded package 9.7 mW/°C above 25°C.

# **Operating Conditions**

Storage Temperature Range

		DS55107, DS55108, DS1603			DS75107, DS75207 DS75108, DS75208 DS3603			
	MIN	NOM	MAX	MIN	NOM	MAX		
Supply Voltage V <sub>CC</sub> +	4.5V	5V	5.5V	4.75∨	5V	5.25V		
Supply Voltage VCC	-4.5V	-5V	-5.5V	-4.75V	-5V	5.25V		
Operating Temperature Range	-55' C	to	+125 °C	0°C	to	+70°C		

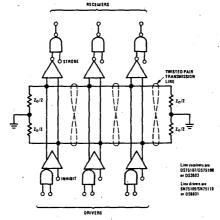
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DS1603, DS55107 and DS55108 and across the 0°C to +70°C range for the DS3603, DS75107, DS75108. All typical values are for  $T_A = 25^{\circ}$ C and  $V_{CC} = 5V$ .

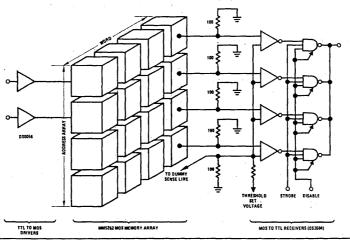
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

### **Typical Applications**

#### Line Receiver Used in a Party-Line or Data-Bus System

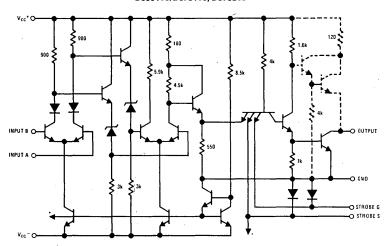


#### Line Receiver Used in MOS Memory System



# **Schematic Diagrams**

DS55107/DS75107, DS75207 DS55108/DS75108, DS75208

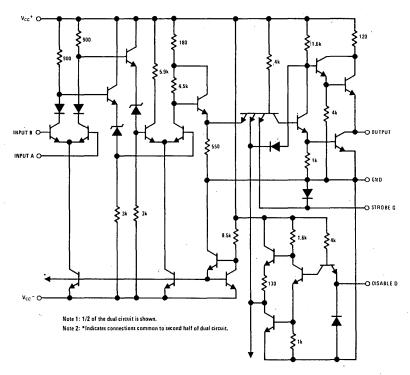


Note 1: 1/2 of the dual circuit is shown.

Note 2: \*Indicates connections common to second half of dual circuit.

Note 3: Components shown with dash lines are applicable to the DS55107, DS75107 and DS75207 only,

#### DS1603/DS3603



# DS55107/DS75107, DS55108/DS75108

# **Electrical Characteristics** $(T_{MIN} \le T_A \le T_{MAX})$

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
I <sub>IH</sub>	High Level Input Current Into A1, B1, A2 or B2	$V_{CC+} = Max, V_{CC+}$ $V_{ID} = 0.5V, V_{IC}$			30	75	μΑ
I <sub>IL</sub>	Low Level Input Current Into A1, B1, A2 or B2	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{ID} = -2V, V_{IC} = -3V \text{ to } 3V$		`		-10	μΑ
I <sub>IH</sub>	High Level Input Current Into G1 or G2	$V_{CC+} = Max$ , $V_{IH(S)} = 2.4V$ $V_{CC} = Max$ $V_{IH(S)} = Max V_{CC+}$				40 1	μA mA
I <sub>IL</sub>	Low Level Input Current Into G1 or G2	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{IL(S)} = 0.4V$				-1.6	mA
I <sub>IH</sub>	High Level Input Current Into S	$V_{CC+} = Max$ , $V_{IH(S)} = 2.4V$ $V_{CC-} = Max$ $V_{IH(S)} = Max V_{CC+}$				80	μA mA
I <sub>IL.</sub>	Low Level Input Current Into S	V <sub>CC+</sub> = Max, V <sub>CC-</sub> = Max V <sub>IL(S)</sub> = 0.4V				-3.2	mA
V <sub>OH</sub>	High Level Output Voltage	$V_{CC+} = Min, V_{CC-} = Min,$ $I_{LOAD} = -400\mu A, V_{ID} = 25 \text{ mV},$ $V_{IC} = -3V \text{ to } 3V, \text{ (Note 3)}$		2.4			V
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC+</sub> = Min, V <sub>C</sub> I <sub>SINK</sub> = 16 mA, V <sub>IC</sub> = -3V to 3	$V_{ID} = -25 \text{ mV},$			0.4	V
Іон	High Level Output Current	$V_{CC+} = Min, V_{CC}$ $V_{OH} = Max^{'}V_{CC}$				250	μΑ
l <sub>os</sub>	Short Circuit Output Current	V <sub>CC+</sub> = Max, V <sub>0</sub> (Notes 2 and 3)		-18		-70	mA
I <sub>CCH+</sub>	High Logic Level Supply Current From V <sub>CC</sub>	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{1D} = 25 \text{ mV}, T_A = 25^{\circ}\text{C}$			18	30	mA
I <sub>CCH</sub> -	High Logic Level Supply Current From V <sub>CC</sub>	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{ID} = 25 \text{ mV}, T_A = 25^{\circ}\text{C}$			-8.4	-15	mA
Vı	Input Clamp Voltage on G or S	$V_{CC+} = Min, V_{CC+}$ $I_{1N} = -12 \text{ mA}, 1$			-1	-1.5	V

# Switching Characteristics $(V_{CC+} = 5V, V_{CC-} = -5V, T_A = 25^{\circ}C)$

	PARAMETER	CONDITIONS	CONDITIONS		TYP	MAX	UNITS
t <sub>PLH(D)</sub>	Propagation Delay Time, Low to High Level, From Differential	$R_L = 390\Omega$ , $C_L = 50 pF$ , (Note 1)	(Note 3) (Note 4)		17 19	25 25	ns
t <sub>PHL(D)</sub>	Inputs A and B to Output  Propagation Delay Time, High to	$R_L = 390\Omega$ , $C_L = 50 pF$ ,	(Note 3)	1	17	25	ns
	Low Level, From Differential Inputs A and B to Output	(Note 1)	(Note 4)		19	25	ns
<sup>t</sup> PLH(S)	Propagation Delay Time, Low to High Level, From Strobe Input G	$R_1 = 390\Omega \cdot C_2 = 50 \text{ pF} = \frac{1}{2}$	(Note 3)		10	15	ns
	or S to Output		(Note 4)		13	20	ns
t <sub>PHL(S)</sub>	Propagation Delay Time, High to Low Level, From Strobe Input G	$R_1 = 390\Omega, C_1 = 50 pF$	(Note 3)		8	15	ns
	or S to Output		(Note 4)	} !	. 13	20	ns

Note 1: Differential input is +100 mV to -100 mV pulse, Delays read from 0 mV on input to 1.5V on output.

Note 2: Only one output at a time should be shorted.

Note 3: DS55107/DS75107 only.

Note 4: DS55108/DS75108 only.

# Electrical Characteristics (0°c $\leq$ T<sub>A</sub> $\leq$ +70°C)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
l <sub>iH</sub>	High Level Input Current Into A1, B1, A2 or B2	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{ID} = 0.5V, V_{IC} = -3V \text{ to } 3V$		30	75	μΑ
I <sub>IL</sub>	Low Level Input Current Into A1, B1, A2 or B2	$V_{CC+} = Max, V_{CC-} = Max$ $V_{ID} = -2V, V_{IC} = -3V \text{ to } 3V$			-10	μΑ
I <sub>IH</sub>	High Level Input Current	$V_{CC+} = Max$ , $V_{IH(S)} = 2.4V$			40	μΑ
	Into G1 or G2	$V_{CC-} = Max$ $V_{IH(S)} = Max V_{CC+}$			1	mA
I <sub>IL</sub>	Low Level Input Current Into G1 or G2	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{IL(S)} = 0.4V$			-1.6	mA
I <sub>IH</sub>	High Level Input Current Into S	$V_{CC+} = Max$ , $V_{IH(S)} = 2.4V$			80	μА
		V <sub>CC</sub> - = Max V <sub>IH(S)</sub> = Max V <sub>CC+</sub>			2	mA
I <sub>IL</sub>	Low Level Input Current Into S	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{1L(S)} = 0.4V$			-3.2	mA
V <sub>OH</sub>	High Level Output Voltage	$V_{CC+} = Min, V_{CC-} = Min,$ $I_{LOAD} = -400\mu A, V_{ID} = 10 \text{ mV},$ $V_{IC} = -3V \text{ to } 3V, \text{ (Note 3)}$	2.4			V
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC+} = Min, V_{CC-} = Min,$ $I_{SINK} = 16 \text{ mA}, V_{ID} = -10 \text{ mV},$ $V_{IC} = -3V \text{ to } 3V$			0.4	v
I <sub>OH</sub>	High Level Output Current	$V_{CC+} = Min, V_{CC-} = Min,$ $V_{OH} = Max V_{CC+}, (Note 4)$			250	μΑ
I <sub>os</sub>	Short Circuit Output Current	V <sub>CC+</sub> = Max, V <sub>CC-</sub> = Max (Notes 2, 3 and 4)	-18		-70	mA
Іссн+	High Logic Level Supply Current From V <sub>CC</sub>	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{ID} = 10 \text{ mV}, T_A = 25^{\circ}\text{C}$		18	30	mA
I <sub>CCH</sub> -	High Logic Level Supply Current From V <sub>CC</sub>	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{ID} = 10 \text{ mV}, T_A = 25^{\circ}\text{C}$		-8.4	-15	mA
Vı	Input Clamp Voltage on G or S	V <sub>CC+</sub> = Min, V <sub>CC</sub> = Min, I <sub>IN</sub> = -12 mA, T <sub>A</sub> = 25°C		-1	-1.5	٧

# Switching Characteristics ( $V_{CC+} = 5V$ , $V_{CC-} = -5V$ , $T_A = 25^{\circ}C$ )

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
<sup>†</sup> PLH(D)	Propagation Delay Time, Low-to- High Level, From Differential Inputs A and B to Output	$R_L = 470\Omega$ , $C_L = 15 pF$ , (Note 1)			35	ns
t <sub>PHL(D)</sub>	Propagation Delay Time, High-to- Low Level, From Differential Inputs A and B to Output	R <sub>L</sub> = 470Ω, C <sub>L</sub> = 15 pF, (Note 1)			20	ns
<sup>t</sup> PLH(S)	Propagation Delay Time, Low-to- High Level, From Strobe Input G or S to Output	R <sub>L</sub> = 470Ω, C <sub>L</sub> = 15 pF			17	ns
<sup>t</sup> PHL(S)	Propagation Delay Time, High-to- Low Level, From Strobe Input G or S to Output	R <sub>L</sub> = 470Ω, C <sub>L</sub> = 15 pF			- 17	ns

Note 1: Differential input is +10 mV to -30 mV pulse. Delays read from 0 mV on input to 1.5V on output.

Note 2: Only one output at a time should be shorted.

Note 3: DS75207 only. Note 4: DS75208 only.

# DS1603/DS3603 Electrical Characteristics $(T_{MIN} \le T_A \le T_{MAX})$

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
I <sub>IH</sub>	High Level Input Current Into A1, B1, A2 or B2	$V_{CC^{+}} = Max, V_{CC^{+}}$ $V_{ID} = 0.5V, V_{IC}$			30	75	μΑ
I <sub>IL</sub>	Low Level Input Current Into A1, B1, A2 or B2	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{ID} = -2V, V_{IC} = -3V \text{ to } 3V$				-10	μΑ
I <sub>IH</sub>	High Level Input Current	V <sub>CC+</sub> = Max,	V <sub>IH(S)</sub> = 2.4V			40	μΑ
	Into G1, G2 or D	V <sub>CC</sub> -= Max	V <sub>IH(S)</sub> = Max V <sub>CC+</sub>			1	mA
I <sub>IL</sub>	Low Level Input Current Into D	$V_{CC+} = Max, V_C$ $V_{IL(D)} = 0.4V$	<sub>CC-</sub> = Max,			-1.6	mA
I <sub>IL</sub>	Low Level Input Current	V <sub>CC+</sub> = Max, V <sub>IH(D)</sub> = 2V				-40	μΑ
	Into G1 or G2	$V_{CC-} = Max,$ $V_{IL(G)} = 0.4V$	V <sub>IL(D)</sub> = 0.8V			-1.6	mA
V <sub>OH</sub>	High Level Output Voltage	$V_{CC+} = Min, V_{CC-} = Min,$ $I_{LOAD} = -2 \text{ mA}, V_{ID} = 25 \text{ mV}$ $V_{IL(D)} = 0.8V, V_{IC} = -3V \text{ to } 3V$		2.4		,	V
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC+} = Min, V_{CC-} = Min,$ $I_{SINK} = 16 \text{ mA}, V_{ID} = -25 \text{ mV},$ $V_{IL(D)} = 0.8V, V_{IC} = -3V \text{ to } 3V$			,	0.4	V
Ioo	Output Disable Current	V <sub>CC+</sub> = Max, V <sub>CC-</sub> = Max	V <sub>OUT</sub> = 2.4V			40	μΑ
		V <sub>IH(D)</sub> = 2V	V <sub>OUT</sub> = 0.4V	<u> </u>	ĺ	-40	μΑ
Ios	Short Circuit Output Current	$V_{CC+} = Max, V_{IL(D)} = 0.8V,$ $V_{CC-} = Max, (Note 2)$		-18		-70	mA
I <sub>CCH+</sub>	High Logic Level Supply Current From V <sub>CC+</sub>	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{ID} = 25 \text{ mV}, T_A = 25^{\circ}\text{C}$			28	40	mA
I <sub>CCH</sub> -	High Logic Level Supply Current From V <sub>CC</sub> -	$V_{CC+} = Max, V_{CC-} = Max,$ $V_{ID} = 25 \text{ mV}, T_A = 25^{\circ}\text{C}$			-8.4	-15	mA
V <sub>1</sub>	Input Clamp Voltage on G or D	$V_{CC+} = Min, V_{CC-} = Min,$ $I_{IN} = -12 \text{ mA}, T_{A} = 25^{\circ}\text{C}$			-1	-1.5	V

# Switching Characteristics (V<sub>CC+</sub> = 5V, V<sub>CC-</sub> = -5V, T<sub>A</sub> = 25°C)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>PLH(D)</sub>	Propagation Delay Time, Low-to- High Level, From Differential Inputs A and B to Output	R <sub>L</sub> = 390Ω, C <sub>L</sub> = 50 pF, (Note 1)		17	25	ns <sub>.</sub>
t <sub>PHL(D)</sub>	Propagation Delay Time, High-to- Low Level, From Differential Inputs A and B to Output	$R_L = 390\Omega$ , $C_L = 50$ pF, (Note 1)		. 17	¹ <b>2</b> 5	ns
t <sub>PLH(S)</sub>	Propagation Delay Time, Low-to- High Level, From Strobe Input G to Output	R <sub>L</sub> = 390Ω, C <sub>L</sub> = 50 pF		10 ′	15	ns
t <sub>PHL(S)</sub>	Propagation Delay Time, High-to- Low Level, From Strobe Input G to Output	$R_L = 390\Omega$ , $C_L = 50 pF$		8	15	ns
t <sub>1H</sub>	Disable Low-to-High to Output High to Off	$R_L = 390\Omega$ , $C_L = 5 pF$			20	ns
t <sub>он</sub>	Disable Low-to-High to Output  Low to Off	$R_L = 390\Omega$ , $C_L = 5 pF$			30	ns
t <sub>H1</sub>	Disable High-to-Low to Output Off to High	R <sub>L</sub> = 1k to 0V, C <sub>L</sub> = 50 pF			25	ns
t <sub>HO</sub>	Disable High-to-Low to Output Off to Low	$R_{L} = 390\Omega, C_{L} = 50 \text{ pF}$			25	ns

Note 1: Differential input is +100 mV to -100 mV pulse. Delays read from 0 mV on input to 1.5V on output.

Note 2: Only one output at a time should be shorted.

# National Semiconductor DS1650/DS3650, DS1652/DS3652 Quad Differential Line Receivers

# **General Description**

The DS1650/DS3650 and DS1652/DS3652 are TTL compatible quad high speed circuits intended primarily for line receiver applications. Switching speeds have been enhanced over conventional line receivers by the use of Schottky technology, and TRI-STATE® strobing is incorporated offering a high impedance output state for bussed organizations.

The DS1650/DS3650 has active pull-up outputs and offers a TRI-STATE strobe, while the DS1652/DS3652 offers open collector outputs providing implied "AND" operation.

The DS1652/DS3652 can be used for address decoding as illustrated below. All outputs of the DS1652/DS3652 are tied together through a common resistor to 5V. In

# Transmission Line Drivers/Receivers

this configuration the DS1652/DS3652 provides the "AND" function. All addresses have to be true before the output will go high. This scheme eliminates the need for an "AND" gate and enhances speed throughput for address decoding.

#### **Features**

- High speed
- TTL compatible
- Input sensitivity
- TRI-STATE outputs for high speed busses
- Titi-STATE outputs for high speed be
- Standard supply voltages

±5V

±25 mV

Pin and function compatible with MC3450 and MC3452

### Connection Diagram

# 

Order Number DS1650J, DS1652J, DS3650J, DS3652J, DS3650N or DS3652N See NS Package J16A or N16A

# **Truth Table**

	T	OUT	PUT
INPUT	STROBE	D\$1650/ D\$3650	DS1652/ DS3652
$V_{\text{ID}} \ge 25 \text{ mV}$	L' H	H Open	Open Open
$-25 \text{ mV} \le \text{V}_{\text{ID}} \le 25 \text{ mV}$	L H	X Open	X Open
$V_{\text{ID}} \leq -25 \text{ mV}$	L	L Open	L Open

L = Low Logic State

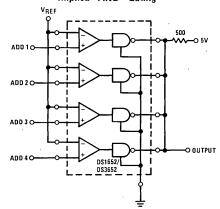
H = High Logic State

Open = TRI-STATE

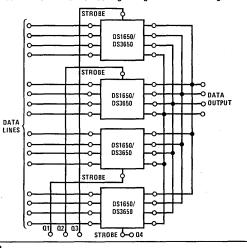
X = Indeterminate State

# **Typical Applications**

Implied "AND" Gating



#### Wired "OR" Data Selecting Using TRI-STATE Logic



<b>Absolute Maximum Ratings</b>	(Note 1)	Operating Condition	ons		
•		•	MIN	MAX	UNITS
Power Supply Voltages VCC VEE	+7.0 V <sub>DC</sub> -7.0 V <sub>DC</sub>	Supply Voltage, V <sub>CC</sub> DS1650, DS1652 DS3650, DS3652	4.5 4.75	5.5 5.25	V <sub>DC</sub>
Differential-Mode Input Signal Voltage Range, VIDR Common-Mode Input Voltage Range, VICR	±6.0 V <sub>DC</sub> ±5.0 V <sub>DC</sub>	Supply Voltage, V <sub>EE</sub> DS1650, DS1652 DS3650, DS3652	-4.5 -4.75	-5.5 -5.25	V <sub>DC</sub>
Strobe Input Voltage, VI(S)	5.5 V <sub>DC</sub> 55°C to +150°C 300°C	Operating Temperature, T <sub>A</sub> DS1650, DS1652 DS3650, DS3652	55 0	+125 +70	°C °C
Maximum Power Dissipation* at 25°C	300 0	Output Load Current, IOL		16	mA
Cavity Package Molded Package	1509 mW 1476 mW	Differential-Mode Input Voltage Range, V <sub>IDR</sub>	-5.0	+5.0	V <sub>DC</sub>
*Derate cavity package 10.1 mW/°C above 25°C, package 11.8 mW/°C above 25°C.	; derate molded	Common-Mode Input Voltage Range, V <sub>ICR</sub>	-3.0	+3.0	v <sub>DC</sub>
<b>Electrical Characteristics</b>		Input Voltage Range (Any Input to GND), V <sub>IR</sub>	-5.0	+3.0	V <sub>DC</sub>

(V<sub>CC</sub> = 5.0 V<sub>DC</sub>, V<sub>EE</sub> = -5.0 V<sub>DC</sub>, Min  $\leq$  T<sub>A</sub>  $\leq$  Max, unless otherwise noted) (Notes 2 and 3)

	PARAMETER	cc	NDITIONS	MIN	TYP	MAX	UNIT
VIS	Input Sensitivity, (Note 5). (Common-Mode Voltage Range = $-3V \le V_{IN} \le 3V$ )	$\begin{aligned} & \text{Min} \leq \text{V}_{\text{CC}} \leq \text{Max} \\ & \text{Min} \geq \text{V}_{\text{EE}} \geq \text{Max} \end{aligned}$			·	±25.0	mV
<sup>1</sup> (H(I)	High Level Input Current to Receiver Input	(Figure 5)				75	μΑ
lil(i)	Low Level Input Current to Receiver Input	(Figure 6)				-10	μΑ
IIH(S)	High Level Input Current to Strobe Input	`	V <sub>1H(S)</sub> = 2.4V, DS1650, DS1652			100	μΑ
		(Figure 3)	V <sub>1H(S)</sub> = 2.4V, DS3650, DS3652	i		40	μΑ
		}	VIH(S) = VCC		1	] 1	m/
IIL(S)	Low Level Input Current to Strobe Input		V <sub>IH</sub> (S) = 0.4V			-1.6	m/
Vон	High Level Output Voltage		DS1650, DS3650	2.4			VDO
ICEX	High Level Output Leakage Current	(Figure 1)	DS1652, DS3652			250	μΑ
VOL	Low Level Output Voltage	(C: 4)	DS3650, DS3652			0.45	Ī
		(Figure 1)	DS1650, DS1652			0.50	VDO
los	Short-Circuit Output Current (Note 4)	(Figure 4)	DS1650/DS3650	-18		-70	m/
IOFF	Output Disable Leakage Current	/5: 71	DS1650			100	μА
		(Figure 7)	DS3650			40	μ
ГССН	High Logic Level Supply Current from VCC	(Figure 2)			45	60	m
IEEH	High Logic Level Supply Current from VEE	(Figure 2)			-17	-30	m

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the 0°C to +70°C range for the DS3650, DS3652 and the -55°C to +125°C range for the DS1650, DS1652. All typical values are for TA = 25°C,  $V_{CC}$  = 5V and  $V_{EE}$  = -5V:

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

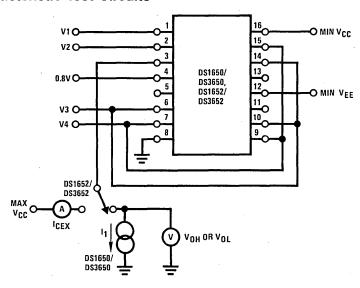
Note 4: Only one output at a time should be shorted.

Note 5: A parameter which is of primary concern when designing with line receivers is, what is the minimum differential input voltage required as the receiver input terminals to guarantee a given output logic state. This parameter is commonly referred to as threshold voltage. It is well known that design considerations of threshold voltage are plagued by input offset currents, bias currents, network source resistances, and voltage gain. As a design convenience, the DS1650, DS1652 and the DS3650, DS3652 are specified to a parameter called input sensitivity (VIS). This parameter takes into consideration input offset currents and bias currents and guarantees a minimum input differential voltage to cause a given output logic state with respect to a maximum source impedance of 200 $\Omega$  at each input.

# **Switching Characteristics** ( $V_{CC} = 5 V_{DC}$ , $V_{EE} = -5 V_{DC}$ , $T_A = 25^{\circ}C$ unless otherwise noted)

	PARAMETER	CON	DITIONS	MIN	TYP	MAX	UNITS
tPHL(D)	High-to-Low Logic Level Propagation Delay Time (Differential Inputs)		DS1650/DS3650 DS1652/DS3652		21 20	25 25	ns ns
tPLH(D)	Low-to-High Logic Level Propagation Delay Time (Differential Inputs)	(Figure 8)	DS1650/DS3650 DS1652/DS3652		20 22	25 25	ns ns
tPOH(S)	TRI-STATE to High Logic Level Propagation Delay Time (Strobe)		DS1650/DS3650		16	21	ns
tPHO(S)	High Logic Level to TRI-STATE Propagation Delay Time (Strobe)	/Figure 01	DS1650/DS3650		7	18	ns
tPOL(S)	TRI-STATE to Low Logic Level Propagation Delay Time (Strobe)	(Figure 9)	DS1650/DS3650		19	27	ns
tPLO(S)	Low Logic Level to TRI-STATE Propagation Delay Time (Strobe)	·	DS1650/DS3650		14	29	ns .
tPHL(S)	High-to-Low Logic Level Propagation Delay Time (Strobe)	(5: 40)	DS1652/DS3652		16	25	ns
tPLH(S)	Low-to-High Logic Level Propagation Delay Time (Strobe)	(Figure 10)	DS1652/DS3652		13	25	ns

# **Electrical Characteristic Test Circuits**

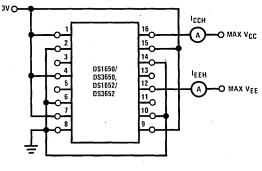


	V	1	\ \	/2	\\	/3	\	/4	
	DS1650/ DS3650	DS1652/ DS3652	DS1650/ DS3650	DS1652/ DS1652	DS1650/ DS1650	DS1652/ DS1652	DS1650/ DS1650	DS1652/ DS1652	l <sub>1</sub>
Voн	+2.975V		+3.0V		+3.0V		GND		+0.4 mA
	-3.0V		-2.975V		GND		-3.0V		+0.4 mA
CEX		+2.975V −3.0V		+3.0V -2.975V		+3.0V GND	: 	GND -3.0V	
VOL	+3.0V -2.975V	+3.0V -2.975V	+2.975V -3.0V	+2.975V −3.0V	GND -3.0V	GND -3.0V	+3.0V GND	+3.0V GND	−16 mA −16 mA

Channel A shown under test. Other channels are tested similarly.

FIGURE 1. ICEX, VOH and VOL

# **Electrical Characteristic Test Circuits (Continued)**



I<sub>1H</sub> OR I<sub>1L</sub> A

V<sub>1H(S)</sub> OR

V<sub>1H(S)</sub> OR

V<sub>1L(S)</sub> IR

V<sub>1H(S)</sub> OR

V<sub>1</sub> B

V<sub>2</sub> B

V<sub>2</sub> B

V<sub>3</sub> B

V<sub>4</sub> B

V<sub>5</sub> B

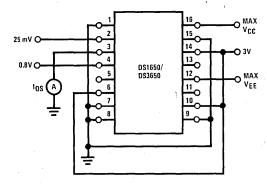
V<sub>6</sub> B

V<sub>7</sub> B

V<sub>8</sub> B

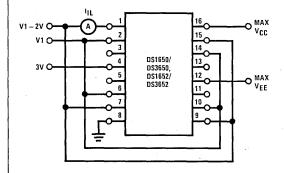
FIGURE 2. ICCH and IEEH

FIGURE 3. IIH(S) and IIL(S)



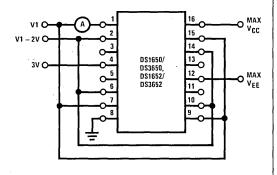
Note. Channel A shown under test, other channels are tested similarly. Only one output shorted at a time.

FIGURE 4. IOS



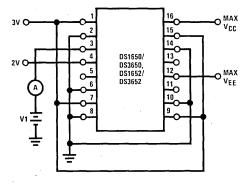
Note. Channel A(-) shown under test, other channels are tested similarly. Devices are tested with V1 from 3V to -3V.

FIGURE 6. IIL



Note. Channel A(-) shown under test, other channels are tested similarly. Devices are tested with V1 from 3V to -3V.

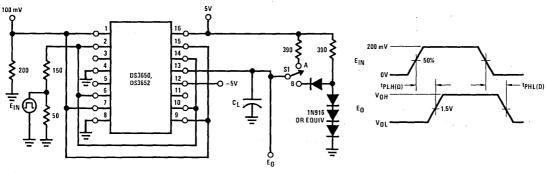
FIGURE 5. I<sub>IH</sub>



Note. Output of Channel A shown under test, other outputs are tested similarly for V1 = 0.4V and 2.4V.

FIGURE 7. IOFF

# **AC Test Circuits and Switching Time Waveforms**



Note. Output of Channel B shown under test, other channels are tested similarly.

S1 at "A" for DS1652/DS3652 S1 at "B" for DS1650/DS3650

C<sub>L</sub> = 15 pF total for DS1652/DS3652

CL = 50 pF total for DS1650/DS3650

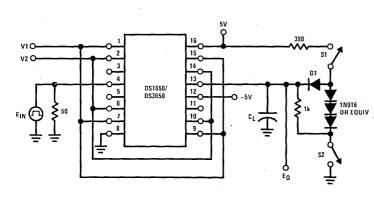
E<sub>IN</sub> waveform characteristics:

 $t_{\mbox{\scriptsize TLH}}$  and  $t_{\mbox{\scriptsize THL}} \leq 10$  ns measured 10% to 90% PRR = 1 MHz

tPLO(S)

Duty Cycle = 500 ns

FIGURE 8. Receiver Propagation Delay tpLH(D) and tpHL(D)



Note. Output of Channel B shown under test, other channels are tested similarly.

-1 CO(0)	
50% tpLo(S)	
V <sub>0L</sub> 0.5V	
tPHO(S)	•
3V	<b></b>
v <sub>0H</sub>	V <sub>OH</sub> 0.5\ ≈ 1.5V

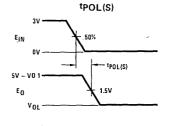
	V1	V2	S1	S2	CL
tPLO(S)	100 mV	GND	Closed	Closed	15 pF
tPOL(S)	100 mV	GND	Closed	Open	50 pF
tPHO(S)	GND	100 mV	Closed	Closed	15 pF
tPOH(S)	GND	100 mV	Open	Closed	50 pF

C<sub>L</sub> includes jig and probe capacitance.

 $E_{IN}$  waveform characteristics:  $t_{TLH}$  and  $t_{THL} \leq 10$  ns measured 10% to 90%

PRR = 1 MHz

Duty Cycle = 50%



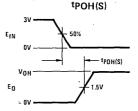
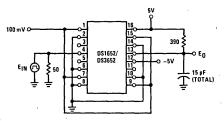


FIGURE 9. Strobe Propagation Delay tpLO(S), tpOL(S), tpHO(S) and tpOH(S)

# AC Test Circuits and Switching Time Waveforms (Continued)



tPHL(S)

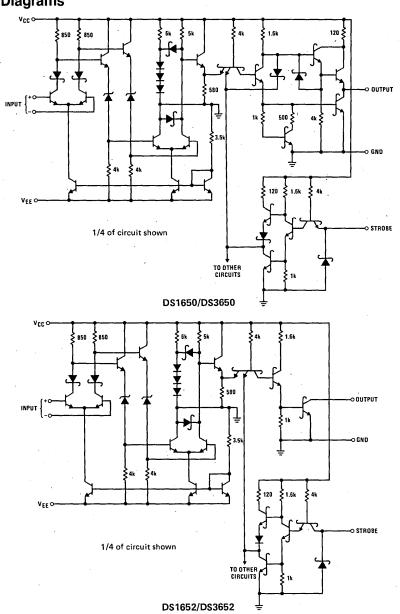
Note. EIN waveform characteristics:  $t_{TLH}$  and  $t_{THL} \le 10$  ns measured 10% to 90% PRR = 1 MHz

Note. Output of Channel B shown under test, other channels are tested similarly.

Duty Cycle = 500 ns

FIGURE 10. Strobe Propagation Delay tpLH(S) and tpHL(S)

# **Schematic Diagrams**



# Transmission Line Drivers/Receivers

# DS1691A/DS3691 (RS-422/RS-423) Line Drivers with TRI-STATE®

# **General Description**

The DS1691A/DS3691 are low power Schottky TTL line drivers designed to meet the requirements of EIA standards RS-422 and RS-423. They feature 4 buffered outputs with high source and sink current capability with internal short circuit protection. A mode control input provides a choice of operation either as 4 independent line drivers or 2 differential line drivers. A rise time control pin allows the use of an external capacitor to reduce rise time for suppression of near end crosstalk to other receivers in the cable.

With the mode select pin low, the DS1691A/DS3691 are dual differential line drivers with TRI-STATE outputs. They feature  $\pm$  10V output common-mode range in TRI-STATE and 0V output unbalance when operated with  $\pm$  5V supply.

### **Features**

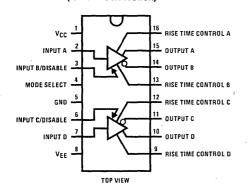
- Dual RS-422 line driver with mode pin low, or quad RS-423 line driver with mode pin high
- Individually TRI-STATEable differential drivers in differential mode
- Short circuit protection for both source and sink outputs
- Outputs will not clamp line with power off or in TRI-STATE
- Individual rise time control for each output
- 100Ω transmission line drive capability
- Low I<sub>CC</sub> and I<sub>EE</sub> power consumption RS-422 RS-423

35 mW/driver typ 26 mW/driver typ

 Low current PNP inputs compatible with TTL, MOS and CMOS

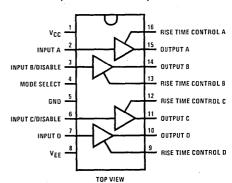
## **Connection Diagram**

With Mode Select LOW (RS-422 Connection)



## Connection Diagram

With Mode Select HIGH (RS-423 Connection)



### **Truth Table**

Operation		Inputs		Outputs		
Operation	Mode	A (D)	B (C)	A (D)	B (C)	
RS-422	0	0	0	0	1	
1	0	0	1	TRI-STATE	TRI-STATE	
	0	1	0	1	0	
	0	1	1 1	TRI-STATE	TRI-STATE	
RS-423	1	0	0	0	0	
	1	0	1	0	1	
i	1	1	0	1	0	
	1	1	1	1	1	

Order Number DS1691AJ, DS3691J or DS3691N See NS Package J16A or N16A

Absolute Maximum Ratings (Note 1)	Operating Conditions	
Supply Voltage  V <sub>CC</sub> 7V  V <sub>EE</sub> Advisor Planta Planta to 25°C	Min Ma: Supply Voltage DS1691A	x Units
Maximum Power Dissipation* at 25°C Cavity Package 1509 mW Molded Package 1476 mW	V <sub>CC</sub> 4.5 5.5 V <sub>EE</sub> -4.5 -5.5 DS3691	
Input Voltage 15V Output Voltage (Power OFF) ± 15V	V <sub>CC</sub> 4.75 5.29 V <sub>EF</sub> -4.75 -5.29	•
Storage Temperature - 65°C to + 150°C Lead Temperature (Soldering, 10 seconds) 300°C	Temperature (T <sub>A</sub> ) DS1691A - 55 + 125 DS3691 0 + 70	
*Derate cavity package 10.1 mW/°C above 25°C; derate molded package		_

# DC Electrical Characteristics (Notes 2, 3, 4 and 5)

·	Parameter		Conditions			Max	Units
RS-422 CONNE	CTION, V <sub>EE</sub> CONNECTION TO G	ROUND, MODE	SELECT≤0.8V				_
V <sub>IH</sub>	High Level Input Voltage			2			V
V <sub>IL</sub>	Low Level Input Voltage	-				0.8	٧
I <sub>IH</sub>	High Level Input Current	$V_{IN} = 2.4V$			1	40	μΑ
		V <sub>IN</sub> ≤15V			10	100	μΑ
I <sub>IL</sub>	Low Level Input Current	$V_{IN} = 0.4V$			- 30	- 200	μΑ
Vi	Input Clamp Voltage	$I_{1N} = -12 \text{ mA}$				- 1.5	V
Vo	Differential Output Voltage	D	V <sub>IN</sub> = 2V		3.6	6.0	V
$\overline{V_O}$	$V_{A,B}$	R <sub>L</sub> = ∞	V <sub>IN</sub> = 0.8V		- 3.6	-6.0	٧
V <sub>T</sub>	Differential Output Voltage	$R_L = 100\Omega$	V <sub>IN</sub> = 2V	2	2.4		V
$\overline{V_T}$	$V_{A,B}$	V <sub>CC</sub> ≥4.75V	V <sub>IN</sub> = 0.8V	-2	- 2.4		٧
$V_{OS}, \overline{V_{OS}}$	Common-Mode Offset Voltage	$R_L = 100\Omega$			2.5	. 3	٧
$ V_T  -  \overline{V_T} $	Difference in Differential Output Voltage	$R_L = 100\Omega$			0.05	0.4	٧
$ V_{OS}  -  \overline{V_{OS}} $	Difference in Common- Mode Offset Voltage	$R_L = 100\Omega$	,		0.05	0.4	٧
V <sub>SS</sub>	$ V_T - \overline{V_T} $	$R_L = 100\Omega, V_{CO}$	<sub>C</sub> ≥ 4.75V	4.0	4.8		٧
V <sub>CMR</sub>	Output Voltage Common- Mode Range	V <sub>DISABLE</sub> = 2.4	V	± 10			٧
I <sub>XA</sub>	Output Leakage Current		V <sub>CMR</sub> = 10V	ļ — — — — — — — — — — — — — — — — — — —	1.	100	μA
I <sub>XB</sub>	Power OFF	$V_{CC} = 0V$	V <sub>CMR</sub> = -10V			- 100	μΑ
lox	TRI-STATE Output Current	.,	V <sub>CMR</sub> ≤10V			100	μΑ
		V <sub>CC</sub> = Max	V <sub>CMR</sub> ≥ - 10V			- 100 ·	μΑ
Isa	Output Short Circuit Current		V <sub>OA</sub> = 6V		80	150	mA
		$V_{1N} = 2.4V^{\circ}$	V <sub>OB</sub> = 0V		- 80	- 150	mA
I <sub>SB</sub>	Output Short Circuit Current	V 0.4V	V <sub>OA</sub> = 0V		-80	- 150	mA
ļ		$V_{IN} = 0.4V$	V <sub>OB</sub> = 6V	1	80	150	, mA
Icc	Supply Current		<u> </u>	<del> </del>	18	30	mA

# AC Electrical Characteristics $T_A = 25$ °C (Note 5)

	Parameter	Conditions	Min	Тур	Max	Units	
RS-42	RS-422 CONNECTION, $V_{CC} = 5V$ , MODE SELECT = 0.8V						
tr	Output Rise Time	$R_L = 100\Omega$ , $C_L = 500$ pF (Figure 1)		120	200	ns	
tf	Output Fall Time	$R_L = 100\Omega$ , $C_L = 500$ pF (Figure 1)		120	200	ns	
t <sub>PDH</sub>	Output Propagation Delay	$R_L = 100\Omega$ , $C_L = 500$ pF (Figure 1)		120	200	ns	
tPDL	Output Propagation Delay	$R_L = 100\Omega$ , $C_L = 500$ pF (Figure 1)		120	200	ns	
t <sub>PZL</sub>	TRI-STATE Delay	$R_L = 450\Omega$ , $C_L = 500$ pF, $C_C = 0$ pF (Figure 4)		250	350	ns	
t <sub>PZH</sub>	TRI-STATE Delay	$R_L = 450\Omega$ , $C_L = 500$ pF, $C_C = 0$ pF (Figure 4)		180	300	ns	
t <sub>PLZ</sub>	TRI-STATE Delay	$R_L = 450\Omega$ , $C_L = 500$ pF, $C_C = 0$ pF (Figure 4)		180	. 300	ns	
t <sub>PHZ</sub>	TRI-STATE Delay	$R_L = 450\Omega$ , $C_L = 500$ pF, $C_C = 0$ pF (Figure 4)		250	350	ns	

# DC Electrical Characteristics (Notes 2, 3, 4 and 5)

	Parameter	Condi	tions	Min	Тур	Max	Units
RS-423 CON	NECTION,  V <sub>CC</sub>   =  V <sub>EE</sub>  , MOD	E SELECT≥2V		1			
V <sub>IH</sub>	High Level Input Voltage			2			V
V <sub>IL</sub>	Low Level Input Voltage					0.8	V
I <sub>IH</sub>	High Level Input Current	V <sub>IN</sub> = 2.4V			1	40	μА
		V <sub>IN</sub> ≤15V			10	100	μΑ
IIL	Low Level Input Current	$V_{IN} = 0.4V$			- 30	- 200	μА
V <sub>I</sub>	Input Clamp Voltage	$I_{IN} = -12 \text{ mA}$				- 1.5	V
Vo	Output Voltage	$R_L = \infty$ , (Note 6)	V <sub>IN</sub> = 2V	4.0	4.4	6.0	V
$\overline{V_0}$	' '	V <sub>CC</sub> ≥ 4.75V	V <sub>IN</sub> = 0.4V	-4.0	-4.4	-6.0	V
V <sub>T</sub>	Output Voltage	$R_L = 450\Omega$ ,	V <sub>IN</sub> = 2.4V	3.6	4.1		V
$\overline{V_T}$		V <sub>CC</sub> ≥4.75V	$V_{IN} = 0.4V$	- 3.6	-4.1		V
$ V_T  -  \overline{V_T} $	Output Unbalance	V <sub>CC</sub>   =  V <sub>EE</sub>   = 4	4.75V, $R_L = 450\Omega$	•	0.02	0.4	V
l <sub>X</sub> +	Output Leakage Power OFF	$V_{CC} = V_{EE} = 0V$	V <sub>O</sub> = 6V		2	100	μА
l <sub>X</sub> -	Output Leakage Power OFF	V <sub>CC</sub> = V <sub>EE</sub> = 0V	$V_0 = -6V$		-2	- 100	μΑ
ls+	Output Short Circuit Current	V <sub>O</sub> = 0V	V <sub>IN</sub> = 2.4V		- 80	- 150	mA
Is <sup>-</sup>	Output Short Circuit Current	$V_O = 0V$	$V_{IN} = 0.4V$		80	150	mA
I <sub>SLEW</sub>	Slew Control Current				± 140		μА
Icc	Positive Supply Current	$V_{IN} = 0.4V, R_{L} = 0.4V$	×		18	30	mA
I <sub>EE</sub>	Negative Supply Current	V <sub>IN</sub> = 0.4V, R <sub>L</sub> = 0	×		- 10	- 22	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the -55°C to +125°C temperature range for the DS1691A and across the 0°C to +70°C range for the DS3691. All typicals are given for V<sub>CC</sub> =5V and T<sub>A</sub> = 25°C. V<sub>CC</sub> and V<sub>EE</sub> as listed in operating conditions.

Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise specified.

Note 4: Only one output at a time should be shorted.

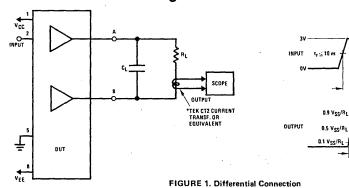
Note 5: Symbols and definitions correspond to EIA RS-422 and/or RS-423 where applicable.

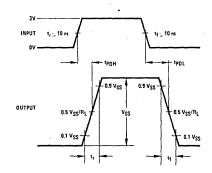
Note 6: At  $-55^{\circ}$ C, the output voltage is +3.9V minimum and -3.9V minimum.

# AC Electrical Characteristics T<sub>A</sub> = 25°C (Note 5)

	Parameter	Conditions	Min	Тур	Max	Units	
RS-423 CONNECTION, V <sub>CC</sub> = 5V, V <sub>EE</sub> - 5V, MODE SELECT = 2.4V							
t <sub>r</sub>	Rise Time	$R_L = 450\Omega$ , $C_L = 500$ pF, $C_C = 0$ (Figure 2)		120	300	ns	
t <sub>f</sub>	Fall Time	$R_L = 450\Omega$ , $C_L = 500$ pF, $C_C = 0$ (Figure 2)		120	300	ns	
t <sub>r</sub>	Rise Time	$R_L = 450\Omega$ , $C_L = 500$ pF, $C_C = 50$ pF (Figure 3)		3.0		μS	
t <sub>f</sub>	Fall Time	$R_L = 450\Omega$ , $C_L = 500$ pF, $C_C = 50$ pF (Figure 3)		3.0		μS	
t <sub>rc</sub>	Rise Time Coefficient	$R_L = 450\Omega$ , $C_L = 500$ pF, $C_C = 50$ pF (Figure 3)		0.06		μs/pF	
t <sub>PDH</sub>	Output Propagation Delay	$R_L = 450\Omega$ , $C_L = 500$ pF, $C_C = 0$ (Figure 2)	,	180	300	ns	
tPDL	Output Propagation Delay	$R_L = 450\Omega$ , $C_L = 500$ pF, $C_C = 0$ (Figure 2)		180	300	ns	

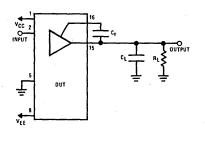
# **AC Test Circuits and Switching Time Waveforms**





0.5 V<sub>SS</sub>/R<sub>L</sub>

FIGURE 2. RS-423 Connection





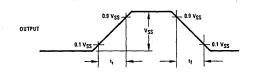


FIGURE 3. Rise Time Control for RS-423

# AC Test Circuits and Switching Time Waveforms (Continued)

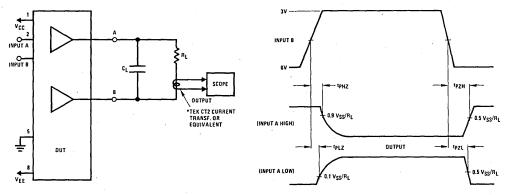
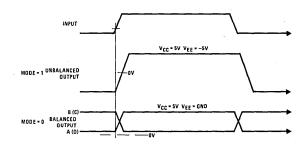
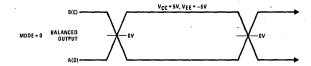


FIGURE 4. TRI-STATE® Delays

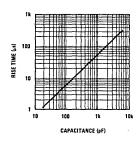
# **Switching Waveforms**





# **Typical Rise Time Control Characteristics**

Rise Time vs External Capacitor





# Transmission Line Drivers/Receivers

# DS1692/DS3692 TRI-STATE® Differential Line Drivers

### **General Description**

The DS1692/DS3692 are low power Schottky TTL line drivers electrically similar to the DS1691A/DS3691 but tested to meet the requirements of MIL-STD-188-114. They feature 4 buffered outputs with high source and sink current capability with internal short circuit protection. A mode control input provides a choice of operation either as 4 independent line drivers or 2 differential line drivers. A rise time control pin allows the use of an external capacitor to reduce rise time for suppression of near end crosstalk to other receivers in the cable.

With the mode select pin low, the DS1692/DS3692 are dual differential line drivers with TRI-STATE outputs. They feature  $\pm 10V$  output common-mode range in TRI-STATE and 0V output unbalance when operated with  $\pm 5V$  supply.

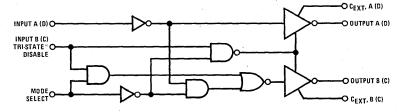
### **Features**

- Dual differential line driver or quad single-ended line driver
- Individually TRI-STATEable differential drivers meet MIL-STD-188-114
- Short circuit protection for both source and sink outputs
- Individual rise time control for each output
- 100Ω transmission line drive capability
- Low I<sub>CC</sub> and I<sub>EE</sub> power consumption Differential mode Single-ended mode

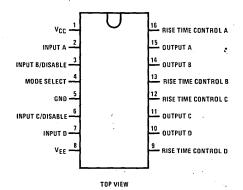
35 mW/driver typ 26 mW/driver typ

 Low current PNP inputs compatible with TTL, MOS and CMOS

### Logic Diagram (1/2 Circuit Shown)



# **Connection Diagram**



Order Number DS1692J, DS3692J or DS3692N See NS Package J16A or N16A

# **Truth Table**

	Inputs		Out	puts
Mode	A (D)	B (C)	A (D)	B (C)
0	0	0 ,	0	1
0	0	1	TRI-STATE	TRI-STATE
0	1	0	1	0
0	1 -	1	TRI-STATE	TRI-STATE
1	0	0	∫	0
1	0	1	\	1
1	1	0	1	0
1	1	1	1	1

<b>Absolute Maximum Ratings</b>	Operating Conditions					
SupplyVoltage V <sub>CC</sub> V <sub>EE</sub>	7V -7V	Supply Voltage DS1692	Min	Max	Units	
Maximum Power Dissipation* at 25°C Cavity Package Molded Package	1509 mW 1476 mW	V <sub>CC</sub> V <sub>EE</sub> DS3692	4.5 - 4.5	5.5 - 5.5	V V	
Input Voltage Output Voltage (Power OFF)	15V ± 15V	V <sub>CC</sub> V <sub>EE</sub>	4.75 - 4.75	5.25 - 5.25	V V	
Storage Temperature — 65 Lead Temperature (Soldering, 10 seconds)	°C to + 150°C 300°C	Temperature (T <sub>A</sub> ) DS1692	<b>–</b> 55	+ 125	°C	
*Derate cavity package 10.1 mW/°C above 25°C; derate	molded package	DS3692	. 0	+ 70	°C	

# Electrical Characteristics DS1692/DS3692 (Notes 2, 3 and 4)

Parameter		Conditions		Min	Тур	Max	Units
DS1692, V <sub>CC</sub> = 9	5V ± 10%, DS3692, V <sub>CC</sub> = 5V ± 5%	6, V <sub>EE</sub> CONNEC	TION TO GROUN	D, MODE SE	LECT≤0.	8V	
V <sub>O</sub>	Differential Output Voltage	B - ~	V <sub>IN</sub> = 2V	2.5	3.6		V
$\overline{v_0}$	V <sub>A,B</sub> .	R <sub>L</sub> = ∞	$V_{IN} = 0.8V$	- 2.5	- 3.6		V
$\frac{V_T}{V_T}$ .	Differential Output Voltage	$R_L = 100\Omega$	$V_{IN} = 2V$	2	2.6		V
V <sub>T</sub>	V <sub>A,B</sub>	V <sub>CC</sub> ≥4.75V	V <sub>IN</sub> = 0.8V	-2	- 2.6		V
$V_{OS}, \overline{V_{OS}}$	Common-Mode Offset Voltage	$R_L = 100\Omega$			2.5	3	٧
$ V_T  -  \overline{V_T} $	Difference in Differential Output Voltage	$R_L = 100\Omega$			0.05	0.4	V
$ V_{OS}  -  \overline{V_{OS}} $	Difference in Common- Mode Offset Voltage	$R_L = 100\Omega$			0.05	0.4	٧
V <sub>SS</sub>	$ V_T - \overline{V_T} $	$R_L = 100\Omega$ , $V_{CO}$	<sub>C</sub> ≥ 4.75V	4.0	4.8		V
lox	TRI-STATE Output Current	V <sub>O</sub> ≤ 10V			- 0.002	- 0.15	mA
		V <sub>O</sub> ≥ 15V			0.002	0.15	mA
I <sub>SA</sub>	Output Short Circuit Current	V <sub>IN</sub> = 2.4V	V <sub>OA</sub> = 6V		80	150	mA
			V <sub>OB</sub> = 0V		- 80	- 150	mA
I <sub>SB</sub>	Output Short Circuit Current	V <sub>IN</sub> = 0.4V	V <sub>OA</sub> = 0V		- 80	<b>– 150</b>	mA
			$V_{OB} = 6V$	, , , , , , , , , , , , , , , , , , , ,	80	150	mA
I <sub>cc</sub>	Supply Current				18	30	mA
DS1692, V <sub>CC</sub> =	$5V \pm 10\%$ , $V_{EE} = -5V \pm 10\%$ , DS	3692, V <sub>CC</sub> = 5V ±	$5\%, V_{EE} = -5 \pm$	5%, MODE	SELECT≤	V8.0	
v <sub>o</sub>	Differential Output Voltage	$R_t = \infty$	$V_{IN} = 2.4V$	7	8.5		V
Vo	$V_{A,B}$	n <sub>L</sub> = ω	$V_{IN} = 0.4V$	, 7	- 8.5		V
$\frac{V_T}{V_T}$	Differential Output Voltage	$R_L = 200\Omega$	V <sub>IN</sub> = 2.4V	6	7.3		V
V <sub>T</sub>	V <sub>A,B</sub>	h[=2001	$V_{IN} = 0.4V$	-6	- 7.3		V
$ V_T - \overline{V_T} $	Output Unbalance	$ V_{CC}  =  V_{EE} $	, $R_L = 200\Omega$		0.02	0.4	V
I <sub>ox</sub>	TRI-STATE Output Current		V <sub>O</sub> = 10V		0.002	0.15	mA
			V <sub>O</sub> = - 10V		- 0.002	- 0.15	mA
ls+	Output Short Circuit Current	V <sub>O</sub> = 0V	V <sub>IN</sub> = 2.4V		- 80	- 150	mA
ls <sup>-</sup>	Output anort oncort ourrent	v <sub>O</sub> =∪v	$V_{IN} = 0.4V$		80	150	mA
SLEW	Slew Control Current				± 140		μА
Icc	Positive Supply Current	$V_{IN} = 0.4V, R_L$	= ∞ .		18	30	mA
I <sub>EE</sub>	Negative Supply Current	$V_{IN} = 0.4V, R_L = \infty$			- 10	- 22	mA

# Electrical Characteristics (Notes 2 and 3) V<sub>EE</sub>≤0V

Parameter		Condi	Conditions		Тур	Max	Units
V <sub>IH</sub>	High Level Input Voltage			2 .			V
V <sub>IL</sub>	Low Level Input Voltage				1	0.8	V
I <sub>IH</sub>	High Level Input Current	V <sub>IN</sub> = 2.4V			1	40	μΑ
		V <sub>IN</sub> ≤ 15V			10	100	μΑ
I <sub>IL</sub>	Low Level Input Current	$V_{1N} = 0.4V$	211		- 30	- 200	μΑ
VI	Input Clamp Voltage	$I_{IN} = -12 \text{ mA}$		•		- 1.5	V
I <sub>XA</sub>	Output Leakage Current		V <sub>O</sub> = 15V		0.01	0.15	mA
$I_{XB}$	Power OFF	$V_{CC} = V_{EE} = 0$	$V_0 = -15V$		- 0.01	- 0.15	· mA

# Switching Characteristics TA = 25°C

Parameter		Conditions	Min	Тур	Max	Units
V <sub>CC</sub> = 5	V, MODE SELECT = 0.8V		-			•
t <sub>r</sub>	Differential Output Rise Time	$R_L = 100\Omega$ , $C_L = 500$ pF (Figure 1)		120	200	ns
t <sub>f</sub>	Differential Output Fall Time	$R_L = 100\Omega$ , $C_L = 500 pF (Figure 1)$		120	200	ns
t <sub>PDH</sub>	Output Propagation Delay	$R_L = 100\Omega$ , $C_L = 500 pF (Figure 1)$		120	200	ns
tPDL	Output Propagation Delay	$R_L = 100\Omega$ , $C_L = 500 pF$ (Figure 1)		120	200	ns
t <sub>PZL</sub>	TRI-STATE Delay	$R_L = 100\Omega$ , $C_L = 500 pF (Figure 2)$		180	250	ns
t <sub>PZH</sub>	TRI-STATE Delay	$R_L = 100\Omega$ , $C_L = 500 pF (Figure 2)$		180	250	ns
t <sub>PLZ</sub>	TRI-STATE Delay	$R_L = 100\Omega$ , $C_L = 500 pF (Figure 2)$		80	150	ns
t <sub>PHZ</sub>	TRI-STATE Delay	$R_L = 100\Omega$ , $C_L = 500 pF (Figure 2)$		80	150	ns
V <sub>CC</sub> = 5	V, $V_{EE} = -5V$ , MODE SELECT = 0.8	V				
t <sub>r</sub>	Differential Output Rise Time	$R_L = 200\Omega$ , $C_L = 500 pF (Figure 1)$		190	300	ns
t <sub>f</sub>	Differential Output Fall Time	$R_L = 200\Omega$ , $C_L = 500 pF (Figure 1)$		190	300	ns
t <sub>PDL</sub>	Output Propagation Delay	$R_L = 200\Omega$ , $C_L = 500 pF (Figure 1)$		190	300	ns
t <sub>PDH</sub>	Output Propagation Delay	$R_L = 200\Omega$ , $C_L = 500 pF (Figure 1)$		190	300	ns
t <sub>PZL</sub>	TRI-STATE Delay	$R_L = 200\Omega$ , $C_L = 500 pF (Figure 2)$		180	250	ns
t <sub>PZH</sub>	TRI-STATE Delay	$R_L = 200\Omega$ , $C_L = 500 pF (Figure 2)$		180	250	ns
t <sub>PLZ</sub>	TRI-STATE Delay	$R_L = 200\Omega$ , $C_L = 500 pF (Figure 2)$		80	150	ns
t <sub>PHZ</sub>	TRI-STATE Delay	$R_L = 200\Omega$ , $C_L = 500 pF (Figure 2)$		80	150	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the -55°C to +125°C temperature range for the DS1692 and across the 0°C to +70°C range for the DS3692. All typicals are given for V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C. V<sub>CC</sub> and V<sub>EE</sub> as listed in operating conditions.

Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise specified.

Note 4: Only one output at a time should be shorted.

# **AC Test Circuits and Switching Time Waveforms**

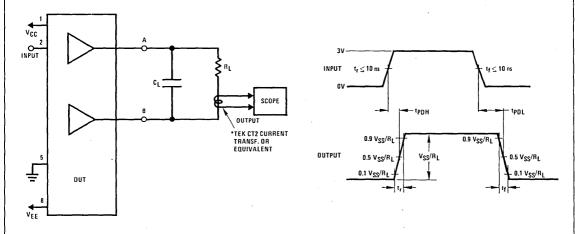


FIGURE 1. Differential Connection

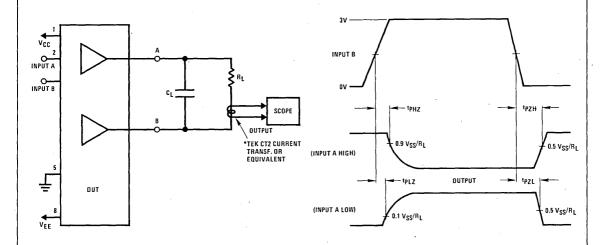
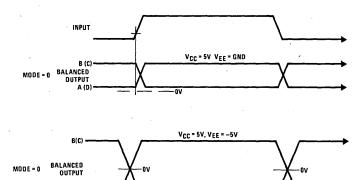


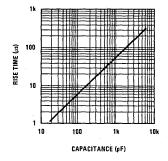
FIGURE 2. TRI-STATE Delays for DS1692/DS3692

# **Switching Waveforms**



# **Typical Rise Time Control Characteristics**

A(D)





# Transmission Line Drivers/Receivers PRELIMINARY

# DS3695/DS3696/DS3697/DS3698 Differential TRI-STATE® Bus/Line Transceivers/Repeaters

## **General Description**

The DS3695, DS3696, DS3697 and DS3698 are high speed differential TRI-STATE bus/line transceivers/repeaters designed to meet the requirements of EIA standard RS485 with extended common mode range (+ 12V to -7V), for multipoint data transmission.

The driver and receiver outputs feature TRI-STATE capability, for the driver outputs over the entire common mode range of  $\pm 12$ V to  $\pm 7$ V. Bus contention or fault situations that cause excessive power dissipation within the device are handled by a thermal shutdown circuit, which forces the driver outputs into the high impedance state. The DS3696 and DS3698 provide an output pin which reports the occurrence of a line fault causing thermal shutdown of the device. This is an "open collector" pin with an internal 10 k $\Omega$  pull-up resistor. This allows the line fault outputs of several devices to be wire OR-ed.

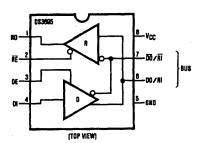
Both AC and DC specifications are guaranteed over the 0 to 70°C temperature and 4.75V to 5.25V supply voltage range.

TRI-STATE® is a registered trademark of National Semiconductor Corp.

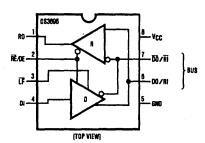
#### **Features**

- Meets new EIA standard RS485 (PN1488), for multipoint bus transmission.
- 15 ns driver propagation delays with 2 ns skew (typical).
- Single channel per package isolates faulty channels (from shutting down good channels).
- Single +5V supply.
- -7V to +12V bus common mode range permits ±7V ground difference between devices on the bus.
- Thermal shutdown protection.
- Power-up down glitch-free driver outputs permit live insertion or removal of transceivers.
- High impedance to bus with driver in TRI-STATE or with power off, over the entire common mode range allows the unused devices on the bus to be powered down.
- Line fault reporting capability on DS3696 and DS3698 allows automated fault location and re-routing under processor control.
- 12 kΩ Minimum receiver input impedance.
- 70 mV typical receiver hysteresis.

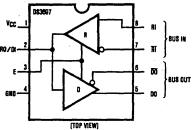
# **Connection and Logic Diagrams**



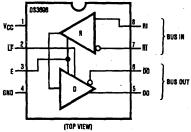
TL/F/5272-1



TL/F/5272-2



TL/F/5272-3



TL/F/5272-4

Order Number DS3695N, DS3696N, DS3697N or DS3698N See NS Package N08E

#### **Absolute Maximum Ratings (Note 1) Recommended Operating Conditions** Supply voltage, V<sub>CC</sub> 7V Min Units Control input voltages 7V Supply voltage, V<sub>CC</sub> 4.75 5.25 Driver input voltage 7V Bus voltage -7 +12 ٧ Driver output voltages +15V/-10VOperating free air temperature TA °C 70 Receiver input voltages (DS3695, DS3696) +15V/-10VReceiver common mode voltage (DS3697, DS3698) ±25V Receiver output voltage Continuous power dissipation @70°C 780 mW Storage temperature range -65°C to +150°C Lead temperature (Soldering 10 seconds) 300°C

### Electrical Characteristics (Notes 2 and 3) - (0°C ≤ T<sub>A</sub> ≤ 70°C, 4.75V < V<sub>CC</sub> < 5.25V unless otherwise specified)

Symbol	Parameter		Conditions		Min	Тур	Max	Units
V <sub>OD1</sub>	Differential Driver Outpu Voltage (Unloaded)	t	I <sub>O</sub> =0			5	٧	
V <sub>OD2</sub>	Differential Driver Outpu Voltage (with Load)	t .	(Figure 1)	1.5			٧	
ΔV <sub>OD</sub>	Change in Magnitude of Differential Output Volta Complementary Output	ge For	(Figure 1)				0.2	٧
V <sub>OC</sub>	Driver Common Mode C Voltage	utput	(Figure 1)				3.0	٧
Δ V <sub>OC</sub>	Change in Magnitude of Common Mode Output \ For Complementary Out States	/oltage	(Figure 1)		-		0.2	V
V <sub>IH</sub>	Input High Voltage				2			V
V <sub>IL</sub>	Input Low Voltage	]	DI, DE,			,	0.8	V
V <sub>CL</sub>	Input Clamp Voltage		RE, E	I <sub>IN</sub> = -18 mA			-1.5	V
I <sub>IL</sub>	Input Low Current			V <sub>IL</sub> =0.4V			-360	μΑ
1 <sub>IH</sub>	Input High Current		•	V <sub>IH</sub> = 2.4V			20	μΑ
lozp	TRI-STATE OUTPUT Current for Driver		V <sub>CC</sub> =0V	V <sub>O</sub> =12V			+1	mA
			or V <sub>CC</sub> = Max	V <sub>O</sub> = -7V			-0.8	mA
V <sub>TH</sub>	Differential Input Thresh Voltage for Receiver	old	V <sub>OUT</sub> =V <sub>OL</sub> or -7V≤V <sub>CM</sub> ≤+	V <sub>OH</sub> 12V	-0.2		+0.2	٧
ΔV <sub>TH</sub>	Receiver Input Hysteres	is	V <sub>CM</sub> =0V			70		mV
V <sub>OH</sub>	Receiver Output High Vo	oltage	$I_{OH} = -400  \mu$		2.4			V
V <sub>OL</sub>	Output Low RO		I <sub>OL</sub> = 16 mA				0.5	V
	Voltage	LF	I <sub>OL</sub> =8 mA				0.45	
lozr	OFF-State (High Impeda Output Current at Recei		V <sub>CC</sub> =Max 0.4V≤V <sub>C</sub> ≤2.4V				± 20	μА
R <sub>IN</sub>	Receiver Input Resistan	ce	-7V≤V <sub>CM</sub> ≤+	-12V	12			kΩ
Icc.	Supply current		No Load	Driver outputs enabled		40		mA
*	(total package)		Driver outputs disabled			23		mA
losp	Driver Short-circuit		Output voltage = -7V				-250	mA
	Output current		Output voltage	= +12V			-250	mA
IOSR	Receiver short-circuit Output current		V <sub>O</sub> =0V,		-15		-85	mA

Note 1. "Absolute maximum ratings" are those beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 2. All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to device ground unless otherwise specified.

Note 3. All typicals are given for  $V_{CC} = 5V$  and  $T_A = 25$ °C.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t <sub>PLH</sub>	Driver Input to Output	R <sub>LDIFF</sub> =60Ω		15		ns
t <sub>PHL</sub>	Driver Input to Output	C <sub>L1</sub> =C <sub>L2</sub> =100 pF		15		ns
Skew	Driver Output to Output	(Figures 3 and 5)		2		ns
tzH	Driver Enable to Output High	C <sub>L</sub> = 100 pF (Figures 4 and 6) S1 open		33		ns
t <sub>ZL</sub>	Driver Enable to Output Low	C <sub>L</sub> = 100 pF (Figures 4 and 6) S2 open		33		ns
t <sub>LZ</sub>	Driver Disable Time from Low	C <sub>L</sub> = 15 pF (Figures 4 and 6) S2 Open		33	-	ns
tHZ	Driver Disable Time from High	C <sub>L</sub> = 15 pF (Figures 4 and 6) S1 Open		33		, ns
tpLH	Receiver Input to Output	C <sub>L</sub> = 15 pF (Figures 2 and 7)		22		ns
t <sub>PHL</sub>	Receiver Input to Output	S1 and S2 Closed		- 22		ns
t <sub>ZL</sub>	Receiver Enable to Output Low	C <sub>L</sub> = 15 pF (Figures 2 and 8) S2 Open		15		ns
tzH	Receiver Enable to Output High	C <sub>L</sub> = 15 pF (Figures 2 and 8) S1 Open		15		ns
tLZ	Receiver Disable from Low	C <sub>L</sub> = 15 pF (Figures 2 and 8) S2 Open		12		ns
tHZ	Receiver Disable from High	C <sub>I</sub> = 15 pF (Figures 2 and 8) S1 Open		12		ns

## **AC Test Circuits**

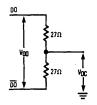


FIGURE 1.

TL/F/5272-5

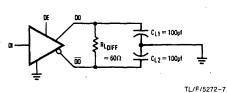
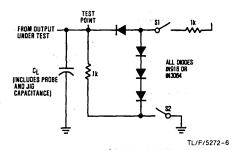
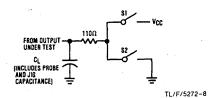


FIGURE 3.



Note: S1 and S2 of load circuit are closed except as otherwise mentioned.

#### FIGURE 2.



**Note:** Unless otherwise specified the switches are closed.

FIGURE 4.

#### **Switching Time Waveforms** f = 1 MHz: $t_f : 10ns$ : $t_f : 10ns$ 1.57 DI ŌŌ **tPLH** 1/2 Vo 1/2 Vg 00 FIGURE 5. Driver Propagation Delays TL/F/5272-9 37 f = 1MHz: tr = 10ns DE or E : tf = 10ns 1.58 0٧ tzL ŧLZ DO, 00 OUTPUT NORMALLY LOW VOH 0.59 00, 00 OUTPUT NORMALLY HIGH tHZ 🔫 OV FIGURE 6. Driver Enable and Disable Times TL/F/5272-10 VOH OUTPUT IPHL - $$\begin{split} f = 1 \text{MHz: } t_r \leq 10 \text{ns} \\ : t_f \leq 10 \text{ns} \end{split}$$ 2.5₹ INPUT RI-RÎ ·2.5V ---Note: Differential input voltage may be realized by grounding $\overline{\text{Ri}}$ and pulsing RI between +2.5V and -2.5VTL/F/5272-11 FIGURE 7. Receiver Propagation Delays $f = 1 \text{MHz: } t_{\text{f}} \cdot ... 10 \text{ns}$ $: t_{\text{f}} \cdot ... 10 \text{ns}$ ŔĒ tLZ\_ 57 RO OUTPUT Normally low 0.50 tzh 0.5V RO OUTPUT Normally High 1.50 tHZ FIGURE 8. Receiver Enable and Disable Times TL/F/5272-12

## **Function Tables**

#### DS3695/DS3696 Transmitting

	Inputs Line				Outputs				
RE	DE	DI	Condition	DO	DO	LF* (DS3696 Only)			
X	1	1	No Fault	0	1	Н			
X	1	0	No Fault	1 .	0	н			
X	0	X	X .	z	Z	н			
Х	1	X	Fault	z	z	L .			

#### DS3695/DS3696 Receiving

l		Inputs		Outputs			
Į	RE	DE	RI-RI	RO	LF* (DS3696 Only)		
	0	0	≥ +0.2V	1	н		
١	0	0	≤ <b>-</b> 0.2V	0	н		
1	0	0	Inputs Open	1 -	н		
	1	0	X	z	H H		

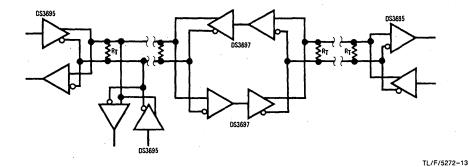
#### DS3697/DS3698

	Inputs	Line			Outputs		
E RI-RI C		Condition	DÖ	DO	RO/DI (DS3697 Only)	LF* (DS3698 Only)	
1	≥ + 0.2V	No Fault	0	1	1	Н	
1	≤-0.2V	No Fault	1	0	0	н	
0	X	. x	z	z	Z .	н	
1	≥ +0.2V	Fault	z	Z	1	L	
_1_	≤-0.2V	Fault	Z	Z	0	L	

X — Don't care condition

Fault — Improper line conditions causing excessive power dissipation in the driver, such as shorts or bus contention situations

## **Typical Application**



Z - High impedance state

 $<sup>{}^\</sup>bullet \overline{LF}$  is an "open collector" output with an on-chip 10 k $\Omega$  pull-up resistor

## DS55113/DS75113 Dual TRI-STATE® **Differential Line Driver**

## **General Description**

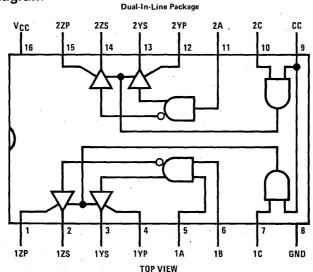
The DS55113/DS75113 dual differential line drivers with TRI-STATE outputs are designed to provide all the features of the DS55114/DS75114 line drivers with the added feature of driver output controls. There are individual controls for each output pair, as well as a common control for both output pairs. When an output control is low, the associated output is in a highimpedance state and the output can neither drive nor load the bus. This permits many devices to be connected together on the same transmission line for party-line applications.

The output stages are similar to TTL totem-pole outputs, but with the sink outputs, YS and ZS, and the corresponding active pull-up terminals, YP and ZP, available on adjacent package pins.

#### **Features**

- Each circuit offers choice of open-collector or active pull-up (totem-pole) outputs
- Single 5V supply
- Differential line operation
- Dual channels
- TTL/LS compatibility
- High-impedance output state for party-line applica-
- Short-circuit protection
- High current outputs
- Single-ended or differential AND/NAND outputs
- Common and individual output controls
- Clamp diodes at inputs
- Easily adaptable to DS55114/DS75114 applications

#### **Connection Diagram**



Positive logic:

Output is OFF when C or CC is low

**Truth Table** 

Order Number DS55113J, DS75113J, or DS75113N See NS Package J16A or N16A

	OUTP	UTS			
OUTPUT C	ONTROL	DAT	Α	AND	NAND
С	CC	Α	В*	Υ	Z
L	×	Х	Х	Z	. Z
. x	L	. X	×	z	Z
( н	н	L	X	L.	Н
н	( н ј	×	L	L	н
Н	н	н	н	- н	L

H = high level

L = low level

X = irrelevant

Z = high impedance (OFF)

\*B input and 4th line of truth table applicable only to driver number 1

Supply Voltage (VCC) (Note 1)	7V
Input Voltage	5.5V
OFF-State Voltage Applied to	
Open-Collector Outputs	12V
Maximum Power Dissipation* at 25°C	
Cavity Package	1433 mW
Molded Package	1362 mW
Operating Free-Air Temperature Range	
DS55113	–55°C to +125°C
DS75113	0°C to +70°C
Storage Temperature Range	–65°C to +150°C
Lead Temperature (1/16" from case for	
60 seconds): J Package	300°C
Lead Temperature (1/16" from case for	
10 seconds): N Package	260°C

**Operating Conditions** 

	MIN	MAX	UNITS
Supply Voltage (VCC)			
DS55113	4.5	5.5	V
DS75113	4.75	5.25	V
High Level Output Current (IOH)		<del>-4</del> 0	mA
Low Level Output Current (IOL)		40	mA
Operating Free-Air Tempera- ture (T <sub>A</sub> )			
DS55113	-55	125	°C
DS75113	0	70	°C

## Electrical Characteristics Over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER CONDITIONS (Note 3)			DS55113	3	DS75113						
			MIN	TYP (Note 4)	мах	MIN	TYP (Note 4)	MAX	UNITS			
ViH	High Level Input	Voltage				2			2			V
VIL	Low Level Input	Voltage						0.8			0.8	V
VIK	Input Clamp Vol	tage	V <sub>CC</sub> = Min, I <sub>I</sub> = -	-12 mA			-0.9	-1.5		-0.9	-1.5	V
Voн	High Level Outp	ut Voltage	V <sub>CC</sub> = Min, V <sub>IH</sub> V <sub>IL</sub> = 0.8V	= 2V,	I <sub>OH</sub> = -10 mA	2.4	3.4		2.4	3.4		V
VOL	Low Level Outpo	ut Voltage	V <sub>CC</sub> = Min, V <sub>IH</sub>	= 2V, V <sub>IL</sub> = 0.8V	, I <sub>OL</sub> = 40 mA		0.23	0.4		0.23	0.4	V
Voк	Output Clamp V	oltage	V <sub>CC</sub> = Max, I <sub>O</sub> =	-40 mA	<del></del>		-1.1	-1.5		-1.1	~1.5	V
lO(off)	OFF-State Open-Collector		Vcc = Max	V <sub>OH</sub> = 12V	T <sub>A</sub> = 25°C T <sub>A</sub> = 125°C		1	10 200				μΑ
9,2,	Output Current	Current	V <sub>OH</sub> ≈ 5.25V		T <sub>A</sub> = 25°C T <sub>A</sub> = 70°C		<b></b> -			1	10 20	
				$T_A = 25^{\circ}C$ , $V_O = 0$ to $V_{CC}$				±10			±10	
					VO = 0			-150			-20	
loz	OFF-State (High		Output Controls	I I A = May		±80			±20	μΑ		
	State) Output Co	ırrent	at 0.8V	[ ^	V <sub>O</sub> = 2.4V			±80			±20	
					NO = NCC	<b> </b>	<del> </del>	80		<u> </u>	20	
lj.	Input Current at Maximum Input Voltage	A, B, C	V <sub>CC</sub> = Max, V <sub>I</sub> =	5.5V				2			2	mA
ΊΗ	High Level Input Current	A, B, C CC	V <sub>CC</sub> = Max, V <sub>I</sub> =	V <sub>CC</sub> = Max, V <sub>I</sub> = 2.4V				40 80			40 80	μΑ
ΠL	Low Level Input Current	A, B, C CC	V <sub>CC</sub> = Max, V <sub>I</sub> =	V <sub>CC</sub> = Max, V <sub>I</sub> = 0.4V				-1.6 -3.2			-1.6 -3.2	mA
los	Short-Circuit Ou Current (Note 5)	•	V <sub>CC</sub> = Max, V <sub>O</sub> = 0			-40	-90	-120	40	-90	-120	mA
loo	Supply Current (	Both	All Inputs at 0V,	No Load,	VCC = Max		47	65		47	65	
lcc	Drivers)		T <sub>A</sub> = 25°C		V <sub>CC</sub> = 7V		65	85		65	85	mA

Note 1: All voltage values are with respect to network ground terminal.

Note 2: For operation above 25°C free-air temperature, refer to Dissipation Derating Curves in the Thermal information section.

Note 3: All parameters with the exception of OFF-state open-collector output current are measured with the active pull-up connected to the sink output.

Note 4: All typical values are at  $T_A = 25^{\circ}$  C and  $V_{CC} = 5V$ , with the exception of  $I_{CC}$  at 7V.

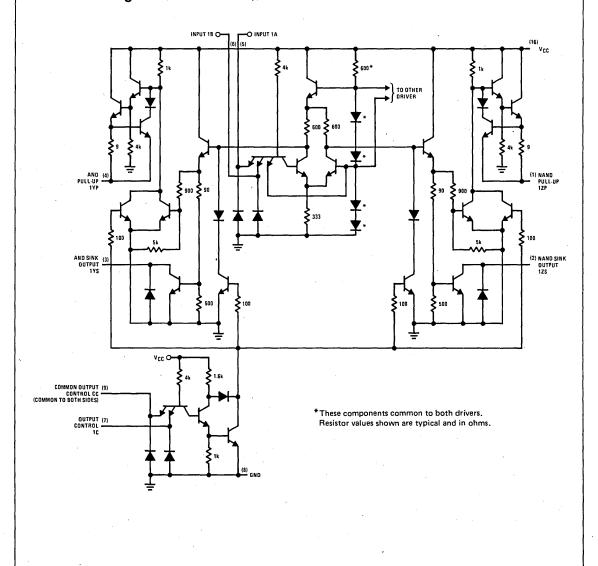
Note 5: Only one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

<sup>\*</sup>Derate cavity package 9.6 mW/ $^{\circ}$ C above 25 $^{\circ}$ C; derate molded package 10.9 mW/ $^{\circ}$ C above 25 $^{\circ}$ C (Note 2).

# Switching Characteristics $V_{CC}$ = 5V, $C_L$ = 30 pF, $T_A$ = 25°C

	PARAMETER	CONDITIONS		DS55113			UNIT			
	PARAMETER	CONDITIONS	MIN	MIN TYP MAX		MIN TYP		MAX	UNIT	
tPLH	Propagation Delay Time, Low-to- High-Level Output	(Simus 4)		13	20		13	30	ns	
tPHL	Propagation Delay Time, High-to- Low-Level Output	(Figure 1)		12	20		12	30	ns	
tPZH	Output Enable Time to High Level	R <sub>L</sub> = 180Ω, (Figure 2)		7	15		7	20	ns	
tPZL	Output Enable Time to Low Level	R <sub>L</sub> = 250Ω, (Figure 3)		14	30		14	40	ns	
tPHZ	Output Disable Time from High Level	R <sub>L</sub> = 180Ω, (Figure 2)		10	20		10	30	ns	
tPLZ	Output Disable Time from Low Level	R <sub>L</sub> = 250Ω, (Figure 3)		17	35		.17	35	ns	

## Schematic Diagram (One side shown only)



tp: H

1.5V

## **AC Test Circuits and Switching Time Waveforms**

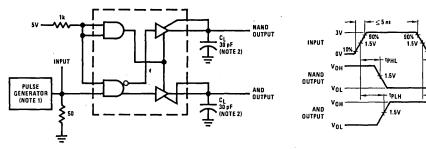
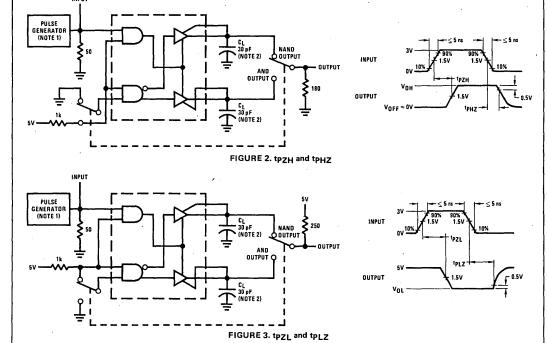
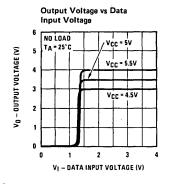


FIGURE 1. tpLH and tpHL

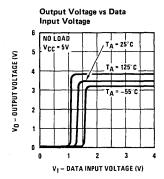


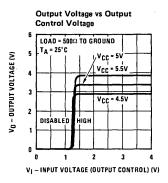
Note 1: The pulse generator has the following characteristics:  $Z_{OUT}$  = 50 $\Omega$ , PRR = 500 kHz,  $t_W$  = 100 ns. Note 2:  $C_L$  includes probe and jig capacitance.

## Typical Performance Characteristics\*



INPUT





<sup>\*</sup>Data for temperatures below 0°C and above 70°C and for supply voltages below 4.75V and above 5.25V are applicable to DS55113 circuits only. These parameters were measured with the active pull-up connected to the sink output.

#### Typical Performance Characteristics\* (Continued) Output Voltage vs Output **Output Voltage vs Output Output Voltage vs Output** Control Voltage Control Voltage Control Voltage LOAD = 500\(\Omega\) TO GROUND LOAD = 50012 TO VCC VCC = 5.5V V<sub>CC</sub> = 5V VCC = 5V 3 **OUTPUT VOLTAGE (V)** VO - OUTPUT VOLTAGE (V) VCC = 5V VO - OUTPUT VOLTAGE TA = 125 C 3 DISABLEI 25 Ċ 2 DISABLE -55 C LOAD = 500Ω TO TA = 25°C ιow 2 3 VI - INPUT VOLTAGE (OUTPUT CONTROL) (V) VI - INPUT VOLTAGE (OUTPUT CONTROL) (V) VI - INPUT VOLTAGE (OUTPUT CONTROL) (V) High Level Output Low Level Output Output Voltage vs Free-Air Voltage vs Output Voltage vs Output Current Temperature Current 0.6 Vcc = 4.5V TA = 25 C TA = 25 C 3.6 V<sub>0</sub> - OUTPUT VOLTAGE (V) - OUTPUT VOLTAGE (V) 0.5 3.2 V<sub>ОН</sub> (ІОН **70H - OUTPUT VOLTAGE** 2 8 0.4 2.4 Vон (Іон -40 mA 0.3 1.6 2 0.2 VCC. 12 0.8 0.1 VOL (10L = 40 mA) -75 -50 -25 0 25 50 75 100 125 -60 -80 -100 -120 TA - FREE-AIR TEMPERATURE ( C) IOH - OUTPUT CURRENT (mA) IOL - OUTPUT CURRENT (mA) Supply Current (Both Supply Current (Both Drivers) vs Free-Air Supply Current (Both Drivers) vs Supply Voltage Drivers) vs Frequency Temperature 80 100 NO LOAD V<sub>CC</sub> = 5V INPUTS GROUNDED VCC = 5V 54 TA = 25 C 70 Œ) (mA) ICC - SUPPLY CURRENT (mA) 52 NO LOAD 80 CL = 30 pF 60 I<sub>CC</sub> – SUPPLY CURRENT 50 INPUTS: 3V SQUARE WAVE SUPPLY CURRENT INPUTS GROUNDED 50 48 60 40 46 INPUTS OPEN 44 40 30 42 20 40 20 10 38 2 -75 -50 -25 4 5 0 25 50 75 V<sub>CC</sub> - SUPPLY VOLTAGE (V) TA - FREE-AIR TEMPERATURE ("C) f - FREQUENCY (MHz) **Propagation Delay Times** from Data Inputs vs Free-Air Output Enable and Disable Times vs Free-Air Temperature Temperature 20 **OUTPUT ENABLE AND DISABLE TIMES (ns)** VCC = 5V VCC = 5V 18 = 30 pF (FIGURES 2 AND 3) 25 PROPAGATION DELAY TIMES FROM DATA INPUTS (ns) 16 (FIGURE 1) tPL2 **TPLH** 14 20 12 tPZŁ tpHI 15 10 tPH7 10 <sup>t</sup>PZH 5 -75 -50 -25 0 25 50 75 100 125 -75 -50 -25 0 25 50 75 100 125 TA - FREE-AIR TEMPERATURE (°C) TA - FREE AIR TEMPERATURE ( C)

<sup>\*</sup>Data for temperatures below 0°C and above 70°C and for supply voltages below 4.75V and above 5.25V are applicable to DS55113 circuits only. These parameters were measured with the active pull-up connected to the sink output.

# DS55114/DS75114 Dual Differential Line Drivers

#### **General Description**

The DS55114/DS75114 dual differential line drivers are designed to provide differential output signals with high current capability for driving balanced lines, such as twisted pair at normal line impedances, without high power dissipation. The output stages are similar to TTL totem-pole outputs, but with the sink outputs, YS and ZS, and the corresponding active pull-up terminals, YP and ZP, available on adjacent package pins. Since the output stages provide TTL compatible output levels, these devices may also be used as TTL expanders or phase splitters.

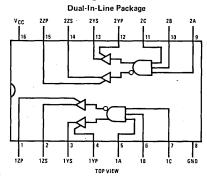
#### **Features**

 Each circuit offers choice of open-collector or active pull-up (totem-pole) outputs

**Transmission Line Drivers/Receivers** 

- Single 5V supply
- Differential line operation
- Dual channels
- TTL/LS compatibility
- Design to be interchangeable with Fairchild 9614 line drivers
- Short-circuit protection of outputs
- High current outputs
- Clamp diodes at inputs and outputs to terminate line transients
- Single-ended or differential AND/NAND outputs
- Triple inputs

## **Connection Diagram**



Positive logic: Y = ABC $Z = \overline{ABC}$ 

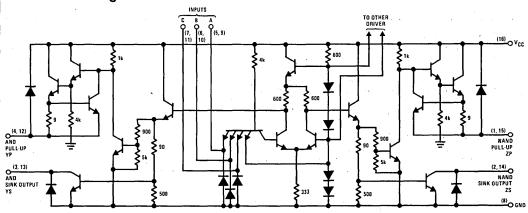
Order Number DS55114J, DS75114J, or DS75114N See NS Package J16A or N16A

## Truth Table

		OUT	PUTS		
	Α	В	С	Υ	Z
	н	н	Н	.H	L
•	All Other	Input Com	binations	L	Н

H = high level

#### Schematic Diagram (Each Driver)



Resistor values shown are typical and in ohms.

•	
Supply Voltage (V <sub>CC</sub> )	7V
Input Voltage	5.5V
OFF-State Voltage Applied to Open-Collector Open-Co	tputs 12V
Maximum Power Dissipation* at 25°C	
Cavity Package	1433 mW
Molded Package	1362 mW
Operating Free-Air Temperature Range	
DS55114 -	55°C to +125°C
DS75114	0°C to +70°C
Storage Temperature Range -	65°C to +150°C
Lead Temperature (1/16" from case	
for 60 seconds): J Package	300°C
Lead Temperature (1/16" from case	
for 10 seconds): N Package	260° C

**Operating Conditions** 

	MIN	MAX	UNITS
Supply Voltage (VCC)			
DS55114	4.5	5.5	V
DS75114	4.75	5.25	V
High Level Output Current (IOH)		-40	mA
Low Level Output Current (IOL)		40	mA
Operating Free-Air Tempera-			
ture (T <sub>A</sub> )			
DS55114	-55	125	°C
DS75114	0	70	°c

## **Electrical Characteristics** Over recommended operating free-air temperature range (unless otherwise noted)

						DS55114		DS75114			1	
PARAMETER			CONDITIONS (N	ote 3)	MIN	TYP (Note 4)	MAX	MIN	TYP (Note 4)	MAX	UNITS	
VIH	High Level Input Voltage							2			V	
VIL	Low Level Input Voltage						0.8			0.8	·	
VIK	Input Clamp Voltage	VCC = Min, I	= -12 mA			-0.9	-1.5		-0.9	-1.5	٧	
Mari	High Level Output Voltage	VCC = Min, V	V <sub>CC</sub> = Min, V <sub>IH</sub> = 2V, I <sub>OH</sub> = -10 mA V <sub>IL</sub> = 0.8V I <sub>OH</sub> = -40 mA		2.4	3.4		2.4	3.4		V	
Voн	High Level Output Voltage	VIL = 0.8V			2	3.0		2	3.0			
VOL	Low Level Output Voltage	V <sub>CC</sub> = Min, V <sub>IH</sub> = 2V, V <sub>IL</sub> = 0.8V, I <sub>OL</sub> = 40 mA				0.2	0.4		0.2	0.45	V	
V 0 1 10 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1		V <sub>CC</sub> = 5V, I <sub>O</sub>	= 40 mA, T <sub>A</sub> = 2	5°C		6.1	6.5		6.1	6.5	v	
νок	Output Clamp Voltage	V <sub>CC</sub> = Max, I	0 = -40 mA, TA	= 25° C		-1.1	-1.5		-1.1	-1.5	ľ	
		V <sub>OH</sub> = 12V		T <sub>A</sub> = 25°C		1	100					
IO(off)	OFF-State Open-Collector	Voc = Max	T <sub>A</sub> = 125°C			200		<del> </del>		μА		
.0(011)	Output Current	l recax	VOH = 5.25V	T <sub>A</sub> = 25°C	Ļ	ļ			1	100	1	
			1011	T <sub>A</sub> = 70°C				<u> </u>		200		
Ц	Input Current at Maximum Input Voltage	VCC = Max, \	/ <sub>I</sub> = 5.5V				1			1	mA	
Ιн	High Level Input Current	VCC = Max, V	/I = 2.4V				40			40	μΑ	
IIL	Low Level Input Current	VCC = Max, \	/I = 0.4V	-		-1.1	-1.6		-1.1	-1.6	mA	
Ios	Short-Circuit Output Current (Note 5)	V <sub>CC</sub> = Max, V <sub>O</sub> = 0			-40	-90	-120	-40	-90	-120	mA	
	Supply Current (Both	Inputs Ground	ded, No Load,	V <sub>CC</sub> = Max		37	50		37	50	^	
ıcc	$T_{A} = 25^{\circ}C$			V <sub>CC</sub> = 7V		47	65		47	70	mA	

Note 1: All voltage values are with respect to network ground terminal.

Note 2: For operation above 25°C free-air temperature, refer to Dissipation Derating Curves in the Thermal Information section.

Note 3: All parameters, with the exception of OFF-state open-collector output current, are measured with the active pull-up connected to the sink output.

Note 4: All typical values are at  $T_A = 25^{\circ}C$  and  $V_{CC} = 5V$ , with the exception of  $I_{CC}$  at 7V.

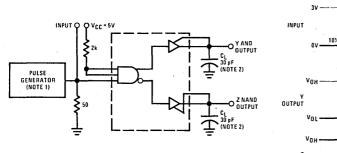
Note 5: Only one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

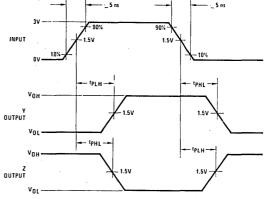
## Switching Characteristics $v_{CC} = 5V$ , $T_A = 25^{\circ}c$

PARAMETER		CONDITIONS	DS55114 DS75114			DS75114		UNITS	
		CONDITIONS	MIN	MIN TYP MAX MIN TYP MAX		MAX -	UNITS		
<sup>†</sup> PLH	Propagation Delay Time, Low-to-High-Level Output	0 20 -5 (5) 11		15	20	·	15	30	ns
<sup>t</sup> PHL	Propagation Delay Time, High-to-Low-Level Output	Cլ = 30 pF, ( <i>Figure 1</i> )		11	20		11	30	ns

<sup>\*</sup>Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.9 mW/°C above 25°C (Note 2).

## **AC Test Circuit and Switching Time Waveforms**



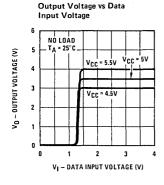


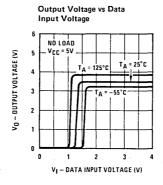
Note 1: The pulse generator has the following characteristics:  $Z_{OUT}$  =  $50\Omega$ ,  $t_W$  = 100 ns, PRR = 500 kHz.

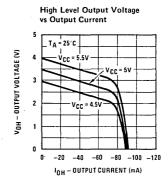
Note 2: CL includes probe and jig capacitance.

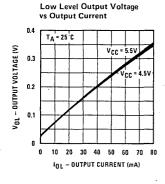
FIGURE 1

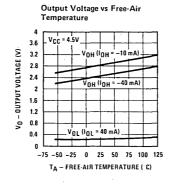
## **Typical Performance Characteristics**

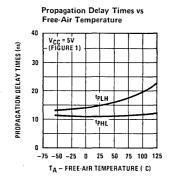






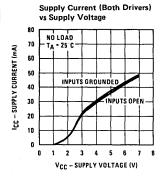


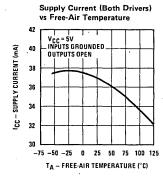


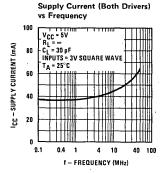


<sup>\*</sup>Data for temperatures below 0°C and above 70°C and for supply voltages below 4.75V and above 5.25V are applicable to DS55114 circuits only. These parameters were measured with the active pull-up connected to the sink output.

## Typical Performance Characteristics\* (Continued)







\*Data for temperatures below 0°C and above 70°C and for supply voltages below 4.75V and above 5.25V are applicable to DS55114 circuits only. These parameters were measured with the active pull-up connected to the sink output.



## DS55115/DS75115 Dual Differential Line Receiver

## **General Description**

The DS55115/DS75115 is a dual differential line receiver designed to sense differential signals from data transmission lines. Designed for operation over military and commercial temperature ranges, the DS55115/DS75115 can typically receive ±500 mV differential data with ±15V common-mode noise. Outputs are open-collector and give TTL compatible signals which are a function of the polarity of the differential input signal. Active output pull-ups are also available, offering the option of an active TTL pull-up through an external connection.

Response time may be controlled with the use of an external capacitor. Each channel may be independently

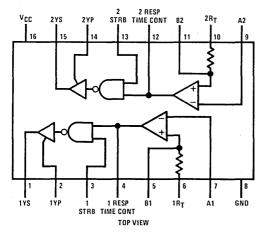
controlled and optional input termination resistors are also available.

#### **Features**

- Single 5V supply
- High common-mode voltage range
- Each channel individually strobed
- Independent response time control
- Uncommitted collector or active pull-up option
- TTL compatible output
- $\blacksquare$  Optional 130 $\Omega$  termination resistors
- Direct replacement for 9615

## **Connection Diagram**

#### **Dual-In-Line Package**



Order Number DS55115J, DS75115J or DS75115N See NS Package J16A or N16A

## **Function Table**

STROBE	DIFF. INPUT	ОИТРИТ
L	Х	Н
Н	L	. Н
H I	Н	L

- H = V<sub>I</sub> ≥ V<sub>IH</sub> min or V<sub>ID</sub> more positive than V<sub>TH</sub> max
- L = V<sub>I</sub> ≤ V<sub>I</sub>L max or V<sub>ID</sub> more negative than V<sub>T</sub>L max
- X = irrelevant

Supply Voltage, VCC (Note 1)	7V
Input Voltage at A, B and R <sub>T</sub> Inputs	±25V
Input Voltage at Strobe Input	5.5V
Off-State Voltage Applied to Open-Collector Outputs	14V
Maximum Power Dissipation* at 25°C	
Cavity Package	1433 mW
Molded Package	1362 mW
Operating Free-Air Temperature Range	

-55°C to +125°C.

-65°C to +150°C

0°C to +70°C

300°C

Operating Free-Air Temperature Range DS55115 DS75115

Storage Temperature Range Lead Temperature (1/16 inch from case for 10 seconds)

\*Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.9 mW/°C above 25°C.

#### **Operating Conditions**

	MIN	MAX	UNITS
Supply Voltage, (VCC)			
DS55115	4.5	5.5	٧
DS75115	4.75	5.25	٧
High Level Output Current, (IOH)		-5	mΑ
Low Level Output Current, (IOL)		15	mΑ
Operating Temperature, (TA)			
DS55115	-55	125	°C
DS75115	0	70	°C

## Electrical Characteristics (Notes 2, 3 and 5)

	ARAMETER	CONDITIONS		ļ	DS55115	i	<u> </u>	DS75115	i	UNITS
. •	ANAIVIETEN	CONDITIONS		MIN	TYP	MAX	MIN	TYP	MAX	UNITS
V <sub>TH</sub>	Differential Input High- Threshold Voltage	V <sub>O</sub> = 0.4V, I <sub>OL</sub> = 15 mA, V <sub>IC</sub> = 0			200	500		200	500	mV
VTL	Differential Input Low-Threshold Voltage	V <sub>O</sub> = 2.4V, I <sub>OH</sub> = -5 mA,	V <sub>O</sub> = 2.4V, I <sub>OH</sub> = -5 mA, V <sub>IC</sub> = 0		-200	500		-200	-500	mV
VICR	Common-Mode Input Voltage Range	V <sub>ID</sub> = ±1V		15 to -15	24 to -19		15 to -15	24 to -19		٧
VIH(STROBE)	High-Level Strobe Input Voltage			2.4			2.4			٧
VIL(STROBE)	Low-Level Strobe Input Voltage					0.4			0.4	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \
		VCC = Min, VID = -0.5V,	T <sub>A</sub> = Min	2.2			2.4			
Voн	High Level Output Voltage	VCC = MIN, VID = -0.5V,	T <sub>A</sub> = 25°C	2.4	3.4		2.4	3.4		V
		I IOH STIIN	T <sub>A</sub> = Max	2.4			2.4			
VoL	Low Level Output Voltage	VCC = Min, VID = 0.5V, IO	L = 15 mA		0.22	0.4		0.22	0.45	٧
lı L		VCC = Max, V <sub>I</sub> = 0.4V, Other Input at 5.5V	TA = Min			-0.9			-0.9	
	Low Level Input Current		T <sub>A</sub> = 25°C		-0.5	-0.7		-0.5	-0.7	mA
			T <sub>A</sub> = Max			-0.7			−0.7	
•	1011 1 1011 101	VCC = Min, VID = -0.5V,	T <sub>A</sub> = 25°C		0.5	2		0.5	5	μΑ
ISH	High Level Strobe Current	VSTROBE = 4.5V	TA = Max			5			10	
¹SL	Low Level Strobe Current	V <sub>CC</sub> = Max, V <sub>ID</sub> = 0.5V, V <sub>STROBE</sub> = 0.4V	T <sub>A</sub> = 25°C		-1.15	-2.4		-1,15	-2.4	mA
14, 112	Response Time Control Current (Pin 4 or Pin 12)	V <sub>CC</sub> = Max, V <sub>ID</sub> = 0.5V, V <sub>RC</sub> = 0	T <sub>A</sub> = 25°C	-1.2	-3.4		-1.2	-3.4		mA
		VCC = Min, VOH = 12V,	T <sub>A</sub> = 25°C			100				
IO(OFF)	Off-State Open-Collector	V <sub>ID</sub> = -4.5V	T <sub>A</sub> = Max			200				μΑ
·0(0FF)	Output Current	V <sub>CC</sub> = Min, V <sub>OH</sub> = 5.25V,	T <sub>A</sub> = 25°C						100	<b>"</b>
		VID = -4.75V	T <sub>A</sub> = Max						200	
RT	Line Terminating Resistance	V <sub>CC</sub> = 5V	T <sub>A</sub> = 25°C	77 .	130	167	74	130	179	Ω
tos	Short-Circuit Output Current	V <sub>CC</sub> = Max, V <sub>O</sub> = 0V, V <sub>ID</sub> = -0.5V, (Note 4)	T <sub>A</sub> = 25°C	-15	-40	-80	-14	-40	-100	mA
lcc	Supply Current (Both Receivers)	V <sub>CC</sub> = Max, V <sub>ID</sub> = 0.5V, V <sub>IC</sub> = 0V	T <sub>A</sub> = 25°C		32	50		32	50	mA

Note 1: "Absolute Maximum Ratings' are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS55115 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS75115. All typical values are for  $T_A = 25^{\circ}$ C,  $V_{CC} = 5V$  and  $V_{CM} = 0V$ .

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

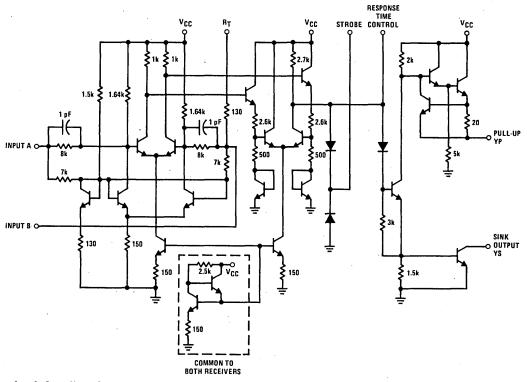
Note 4. Only one output at a time should be shorted.

Note 5: Unless otherwise noted, VSTROBE = 2.4V. All parameters with the exception of off-state open-collector output current are measured with the active pull-up connected to the sink output.

# Switching Characteristics $V_{CC} = 5V$ , $C_L = 30 pF$ , $T_A = 25^{\circ}C$

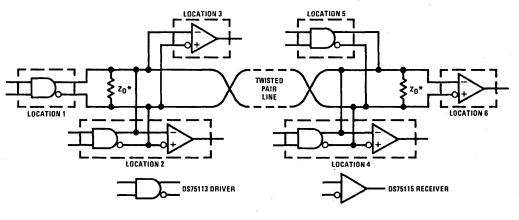
PARAMETER		CONDITIONS	DS55115			DS75115			UNITS	
	FARAMETER	CONDITIONS	MIN	MIN TYP MAX			TYP	MAX	ONITS	
<sup>t</sup> PLH	Propagation Delay Time, Low- to-High Level Output	R <sub>L</sub> = 3.9 k $\Omega$ , (Figure 1)		18	50		18	75	ns	
<sup>‡</sup> PHL	Propagation Delay Time, High- to-Low Level Output	R <sub>L</sub> = 390Ω, (Figure 1)		20	50		20	75	ns	

## **Schematic Diagram**

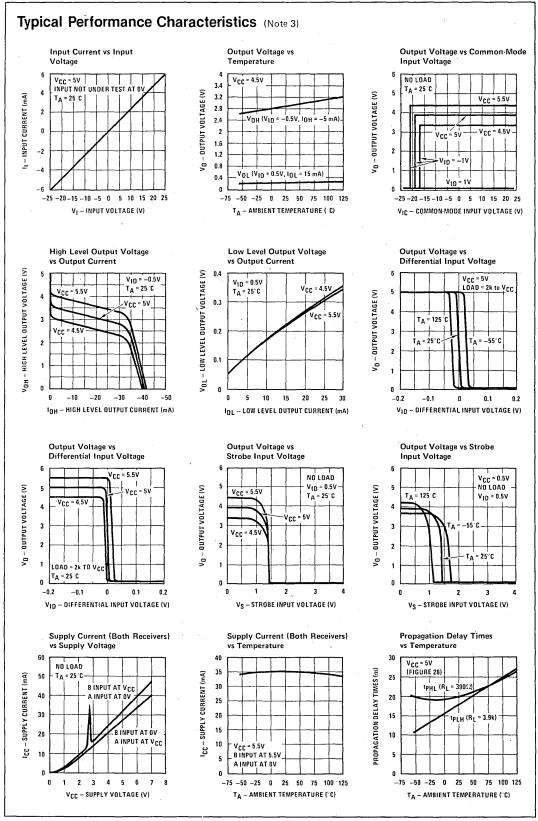


# **Typical Application**

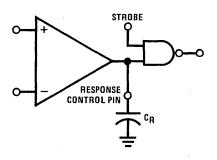
Basic Party-Line or Data-Bus Differential Data Transmission



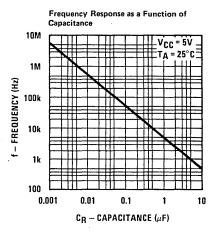
<sup>\*</sup>Z<sub>O</sub> is internal to the DS55115/DS75115 A capacitor may be connected in series with Z<sub>O</sub> to reduce power dissipation.



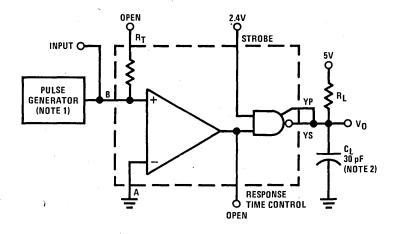
## **Frequency Response Control**



Note.  $C_R$  (response control) > 0.01  $\mu F$  may cause slowing of rise and fall times of the output.



## **AC Test Circuit and Switching Time Waveforms**



Note 1: The pulse generator has the following characteristics:  $Z_{OUT}$  = 50 $\Omega$ , PRR = 500 kHz/t<sub>w</sub> = 100 ns. Note 2:  $C_L$  includes probe and test fixture capacitance.

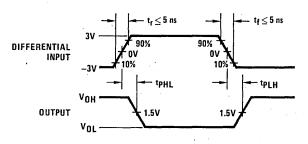


FIGURE 1. Propagation Delay Times



## DS55121/DS75121 Dual Line Drivers

## **General Description**

The DS55121/DS75121 are monolithic dual line drivers designed to drive long lengths of coaxial cable, strip line, or twisted pair transmission lines having impedances from 50 to 500 ohms. Both are compatible with standard TTL logic and supply voltage levels.

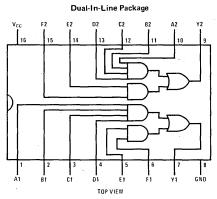
The DS55121/DS75121 will drive terminated low impedance lines due to the low-impedance emitter-follower outputs. In addition the outputs are uncommitted allowing two or more drivers to drive the same line.

Output short-circuit protection is incorporated to turn off the output when the output voltage drops below approximately 1.5V.

#### **Features**

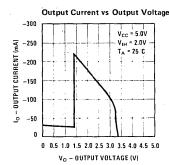
- Designed for digital data transmission over 50 to 500 ohms coaxial cable, strip line, or twisted pair transmission lines
- TTL compatible
- Open emitter-follower output structure for party-line operation
- Short-circuit protection
- AND-OR logic configuration
- High speed (max propagation delay time 20 ns)
- Plug-in replacement for the SN55121/SN75121 and the 8T13

## **Connection Diagram**



Order Number DS55121J, DS75121J or DS75121N See NS Package J16A or N16A

# Typical Performance Characteristics

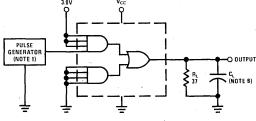


#### **Truth Table**

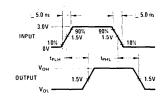
		INF	UTS			OUTPUT
Α	В	С	D	E	F	Y
н	н	Н	Н	Х	×	н
Х	Х	Х	Х	Н	Н	н
All	Other	Input	Coml	omatic	ons	L

H = high level, L = low level, X = irrelevant

## **AC Test Circuit and Switching Time Waveforms**



Note 1: The pulse generators have the following characteristics:  $Z_{OUT} \approx 50\Omega_c$ ,  $t_W = 200$  ns, duty cycle = 50%,  $t_r = t_f = 5.0$  ns. Note 2:  $|C_L|$  includes probe and jig capacitance.



#### **Operating Conditions**

			IVITIV	WAX	01/11/12
Supply Voltage, VCC	6.0V	Supply Voltage, VCC	4.75	5.25	V
Input Voltage	6.0V	Temperature, TA			
Output Voltage	6.0V	DS55121	-55	+125	°C
Output Current	−75 mA	DS75121	0	+75	°C
Maximum Power Dissipation* at 25°C					
Cavity Package	1371 mW				
Molded Package	1280 mW				

<sup>\*</sup>Derate cavity package 9.1 mW/°C above 25°C; derate molded package 10.2 mW/°C above 25°C.

Lead Temperature (Soldering, 10 seconds)

## Electrical Characteristics V<sub>CC</sub> = 4.75V to 5.25V (unless otherwise noted) (Notes 2 and 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	High Level Input Voltage		2.0			V
V <sub>IL</sub>	Low Level Input Voltage				0.8	٧
Vı	Input Clamp Voltage	V <sub>CC</sub> = 5.0V, I <sub>I</sub> = -12 mA			-1.5	٧
l <sub>1</sub>	Input Current at Max Input Voltage	V <sub>CC</sub> = 5.25V, V <sub>IN</sub> = 5.5V			1	mA
V <sub>OH</sub>	High Level Output Voltage	V <sub>IH</sub> = 2.0V, I <sub>OH</sub> = -75 mA (Note 4)	2.4			V
I <sub>OH</sub> .	High Level Output Current	$V_{CC} = 5.0V$ , $V_{IH} = 4.75V$ , $V_{OH} = 2.0V$ , $T_A = 25^{\circ}C$ (Note 4)	-100		250	mA
IOL	Low Level Output Current	V <sub>IL</sub> = 0.8V, V <sub>OL</sub> = 0.4V (Note 4)			-800	μΑ
I <sub>O(OFF)</sub>	Off State Output Current	V <sub>CC</sub> = 0V, V <sub>O</sub> = 3.0V			500	μΑ
I <sub>IH</sub>	High Level Input Current	V <sub>1</sub> = 4.5V			40	μΑ
I <sub>IL</sub>	Low Level Input Current	V <sub>1</sub> = 0.4V	-0.1		-1.6	mA
Ios	Short Circuit Output Current	V <sub>CC</sub> = 5.0V, T <sub>A</sub> = 25°C			-30	mA
I <sub>CCH</sub>	Supply Current, Outputs High	V <sub>CC</sub> = 5.25V, All Inputs at 2.0V, Outputs Open			28	mA
I <sub>CCL</sub>	Supply Current, Outputs Low	V <sub>CC</sub> = 5.25V, All Inputs at 0.8V, Outputs Open			60	mA

# Switching Characteristics $V_{CC}$ = 5.0V, $T_A$ = 25°C

	PARAMETER	CONDITIONS		TYP	MAX	UNITS	
t <sub>PLH</sub>	Propagation Delay Time, Low- to-High Level Output	$R_L = 37\Omega$ , (See ac Test Circuit and Switching Time Waveforms)	C <sub>L</sub> = 15 pF C <sub>L</sub> = 1000 pF		11 22	20 50	ns ns
t <sub>PHL</sub>	Propagation Delay Time, High- to-Low Level Output	$R_L = 37\Omega$ , (See ac Test Circuit and Switching Time Waveforms)	C <sub>L</sub> = 15 pF C <sub>L</sub> = 1000 pF		8.0 20	20 50	ns ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS55121 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS75121. All typical values are for  $T_A = 25^{\circ}$ C and  $V_{CC} = 5V$ .

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: The output voltage and current limits are guaranteed for any appropriate combination of high and low inputs specified by the truth table for the desired output.



## DS55122/DS75122 Triple Line Receivers

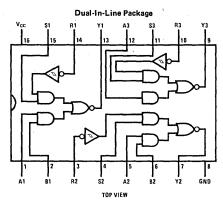
### **General Description**

The DS55122/DS75122 are triple line receivers designed for digital data transmission with line impedances from  $50\Omega$  to  $500\Omega$ . Each receiver has one input with built-in hysteresis which provides a large noise margin. The other inputs on each receiver are in a standard TTL configuration. The DS55122/DS75122 are compatible with standard TTL logic and supply voltage levels.

#### **Features**

- Built-in input threshold hysteresis
- High speed ... typical propagation delay time 20 ns
- Independent channel strobes
- Input gating increases application flexibility
- Single 5.0V supply operation
- Fanout to 10 series 54/74 standard loads
- Plug-in replacement for the SN55122/SN75122 and the 8T14

## **Connection Diagram**



Order Number DS55122J, DS75122J or DS75122N See NS Package J16A or N16A

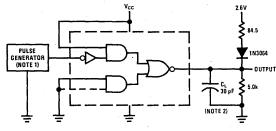
#### **Truth Table**

A	INPI B†	JTS R	s	OUTPUT Y
Н	Н	Х	Х	L
×	X	L	Н	L
L	- X	H,	X	н
L	×	X	L	н
×	L	Н	X	н
×	L	X	L	н.

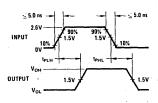
H = high level, L = low level, X = irrelevant

B input and last two lines of the truth table
are applicable to receivers 1 and 2 only.

## **AC Test Circuit and Switching Time Waveforms**



Note 1: The pulse generator has the following characteristics:  $Z_{OUT} \approx 50\Omega$ ,  $t_W=200$  ns, duty cycle = 50%,  $t_r=t_t=5.0$  ns. Note 2:  $C_L$  includes probe and jig capacitance.



#### **Absolute Maximum Ratings** (Note 1) **Operating Conditions** MAX UNITS Supply Voltage, VCC 6.0V Supply Voltage, VCC 4.75 5.25 Input Voltage Operating Temperature, TA R Input 6.0V °C -55 +125 DS55122 A, B, or S Input 5.5V °C DS75122 +75 Output Voltage 6.0V High Level Output Current, Output Current ±100 mA Maximum Power Dissipation\* at 25°C Іон Low Level Output Current, 16 mΑ Cavity Package 1433 mW Molded Package 1362 mW IOL Storage Temperature Range -65°C to +150°C

Lead Temperature (Soldering, 10 seconds)

## Electrical Characteristics V<sub>CC</sub> = 4.75V to 5.25V (unless otherwise noted) (Notes 2 and 3)

300°C

	PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	High Level Input Voltage	A, B, R, or S		2.0			V
V <sub>IL</sub>	Low Level Input Voltage	A, B, R, or S				0.8	V
V <sub>T+</sub> -V <sub>T-</sub>	Hysteresis	V <sub>CC</sub> = 5.0V, T <sub>A</sub>	= 25°C, R,(Note 6)	0.3	0.6		V
V <sub>1</sub>	Input Clamp Voltage	V <sub>CC</sub> = 5.0V, I <sub>1</sub>	= -12 mA, A, B, or S			-1.5	V
I <sub>1</sub>	Input Current at Max Input Voltage	V <sub>CC</sub> = 5.25V, V	<sub>IN</sub> = 5.5V, A, B, or S			1.0	mA
V <sub>OH</sub>	High Level Output Voltage		V <sub>IH</sub> = 2V, V <sub>IL</sub> = 0.8V, (Note 4)	2.6			V
		I <sub>OH</sub> = -500μA	$V_{I(A)} = 0V, V_{I(B)} = 0V,$ $V_{I(R)} = 1.45V, V_{I(S)} = 2.0V, (Note 7)$	2.6			V
VoL	Low Level Output Voltage		V <sub>1H</sub> = 2.0V, V <sub>II</sub> = 0.8V, (Note 4)			0.4	V
		I <sub>OL</sub> = 16 mA	$V_{I(A)} = 0V, V_{I(B)} = 0V,$ $V_{I(B)} = 1.45V, V_{I(S)} = 2.0V, (Note 8)$			0.4	٧
I <sub>IH</sub>	High Level Input Current	V <sub>1</sub> = 4.5V, A, B	, or S			40	μΑ
		V <sub>1</sub> = 3.8V, R				170	μΑ
I <sub>IL</sub>	Low Level Input Current	V <sub>1</sub> = 0.4V, A, B	, or S	~0.1		-1.6	mA
Ios	Short Circuit Output Current	V <sub>CC</sub> ≈ 5.0V, T <sub>A</sub>	= 25°C, (Note 5)	-50		-100	mA
Icc	Supply Current	V <sub>CC</sub> = 5.25V				72	mA

# Switching Characteristics $V_{CC} = 5.0V$ , $T_A = 25^{\circ}C$

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High Level Output from R Input	(See ac Test Circuit and Switching Time Waveforms)		20	30	ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low Level Output from R Input	(See ac Test Circuit and Switching Time Waveforms)		20	30	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: All currents into device pins are shown as positive, currents out of device pins shown as negative, all voltage values are referenced with respect to network ground terminal, unless otherwise noted. All values shown as max or min on absolute value basis.

Note 3: Min/max limits apply across the guaranteed operating temperature range of  $-55^{\circ}$ C to  $+125^{\circ}$ C for DS55122 and  $0^{\circ}$ C to  $+75^{\circ}$ C for DS75122, unless otherwise specified. Typicals are for  $V_{CC} = 5.0V$ ,  $T_{A} = 25^{\circ}$ C. Positive current is defined as current into the referenced pin.

Note 4: The output voltage and current limits are guaranteed for any appropriate combination of high and low inputs specified by the truth table for the desired output.

Note 5: Not more than one output should be shorted at a time.

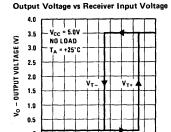
Note 6: Hysteresis is the difference between the positive going input threshold voltage, V<sub>T+</sub>, and the negative going input threshold voltage, V<sub>T-</sub>

Note 7: Receiver input was at a high level immediately before being reduced to 1.45V.

Note 8: Receiver input was at a low level immediately before being raised to 1.45V.

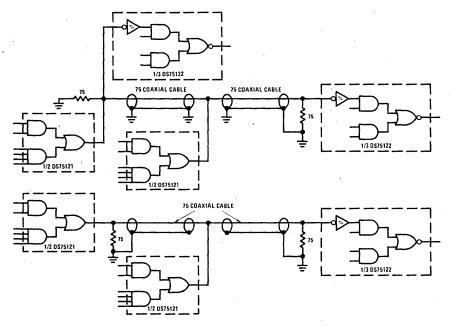
<sup>\*</sup>Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.9 mW/°C above 25°C.

## **Typical Performance Characteristics**

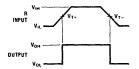


0 0.2 0.4 0.6 0.8 1.0 1.2 1.4 1.6 1.8 2.0 V<sub>i</sub> — INPUT VOLTAGE (V)

# **Typical Applications**



Single-Ended Party Line Circuits



The high gain and built-in hysteresis of the DS55122/DS75122 line receivers enable them to be used as Schmitt triggers in squaring up pulses.

**Pulse Squaring** 

## **DS75123 Dual Line Driver**

### **General Description**

The DS75123 is a monolithic dual line driver designed specifically to meet the I/O interface specifications for IBM System 360. It is compatible with standard TTL logic and supply voltage

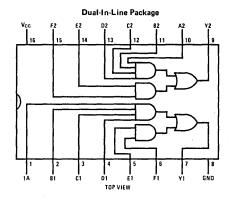
The low-impedance emitter-follower outputs of the DS75123 enable driving terminated low impedance lines. In addition the outputs are uncommitted allowing two or more drivers to drive the same line.

Output short-circuit protection is incorporated to turn off the output when the output voltage drops below approximately 1.5V.

#### **Features**

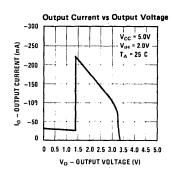
- Meet IBM System 360 I/O interface specifications for digital data transmission over  $50\Omega$  to  $500\Omega$  coaxial cable, strip line, or terminated pair transmission lines
- TTL compatible with single 5.0V supply
- 3.11V output at I<sub>OH</sub> = -59.3 mA
- Open emitter-follower output structure for party-line operation
- Short circuit protection
- AND-OR logic configuration
- Plug-in replacement for the SN75123 and the 8T23

#### **Connection Diagram**



Order Number DS75123J or DS75123N See NS Package J16A or N16A

#### **Typical Performance** Characteristics

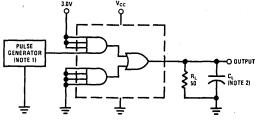


#### **Truth Table**

		INPUTS				OUTPUT
A	В	С	D	E	F	Y
н	н	н	н	х	х	н
x	х	X	X	н	н	н ,
All	All Other Input Combinations				L	

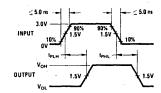
H = high level, L = low level, X = irrelevant

## **AC Test Circuit and Switching Time Waveforms**



Note 1: THE PULSE GENERATORS HAVE THE FOLLOWING CHARACTERISTICS: Zout > 50:2, tw = 200 ns, DUTY CYCLE = 50%.

Note 2: CL INCLUDES PROBE AND JIG CAPACITANCE.



## **Operating Conditions**

UNITS

mA °C

MAX 5.25

-100

+75

Supply Voltage, VCC	7.0V	Supply Voltage	. Vcc
Input Voltage	5.5V	High Level Out	
Output Voltage	7.0V	Тон	,
Maximum Power Dissipation* at 25°C		Temperature, T	A
Cavity Package	1371 mW		
Molded Package	1280 mW		
Operating Free-Air Temperature Range	0°C to +75°C		
Storage Temperature Range	-65°C to +150°C		
Lead Temperature (Soldering, 10 seconds)	300°C		

<sup>\*</sup>Derate cavity package 9.1 mW/°C above 25°C; derate molded package 10.2 mW/°C above 25°C.

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	High Level Input Voltage		2.0			٧
VIL	Low Level Input Voltage				0.8	V
V <sub>I</sub>	Input Clamp Voltage	V <sub>CC</sub> = 5.0V, I <sub>I</sub> = -12 mA			-1.5	V
I <sub>1</sub>	Input Current at Max Input Voltage	V <sub>CC</sub> = 5.25V, V <sub>IN</sub> = 5.5V			1	mA
V <sub>OH</sub>	High Level Output Voltage	$V_{CC} = 5.0V$ , $V_{1H} = 2.0V$ , $T_A = 25^{\circ}C$ $I_{OH} = -59.3$ mA, (Note 4) $T_A = 0^{\circ}C$ to $+75^{\circ}C$	3.11 2.9	-		V V
1 <sub>OH</sub>	High Level Output Current	$V_{CC} = 5.0V$ , $V_{1H} = 4.5V$ , $T_A = 25^{\circ}C$ , $V_{OH} = 2.0V$ , (Note 4)	-100		-250	mA
VoL	Low Level Output Voltage	$V_{1L} = 0.8V, I_{OL} = -240\mu A, (Note 4)$			0.15	٧
I <sub>O(OFF)</sub>	Off State Output Current	V <sub>CC</sub> = 0, V <sub>O</sub> = 3.0V			40	μΑ
I <sub>IH</sub>	High Level Input Current	V <sub>1</sub> = 4.5V			40	μΑ
IIL	Low Level Input Current	V <sub>1</sub> = 0.4V	-0.1		-1.6	mA
los	Short Circuit Output Current	V <sub>CC</sub> = 5.0V, T <sub>A</sub> = 25°C			-30	· mA
Іссн	Supply Current, Outputs High	V <sub>CC</sub> = 5.25V, All Inputs at 2.0V, Outputs Open			28	mA
Iccl	Supply Current, Outputs Low	V <sub>CC</sub> = 5.25V, All Inputs at 0.8V, Outputs Open			60	mA

# Switching Characteristics $v_{cc} = 5.0V$ , $T_A = 25^{\circ}C$

PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS
t <sub>PLH</sub>	Propagation Delay Time, Low- to-High Level Output	$R_L = 50\Omega$ , (See ac Test Circuit and Switching Time Waveforms	C <sub>L</sub> = 15 pF C <sub>L</sub> = 100 pF		12 20	20 35	ns ns
t <sub>PHL</sub>	Propagation Delay Time, High- to-Low Level Output	$R_L = 50\Omega$ , (See ac Test Circuit and Switching Time Waveforms	C <sub>L</sub> = 15 pF C <sub>L</sub> = 100 pF		12 15	20 25	ns ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: All currents into device pins are shown as positive, currents out of device pins shown as negative, all voltage values are referenced with respect to network ground terminal, unless otherwise noted. All values shown as max or min on absolute value basis.

Note 3: Min/max limits apply across the guaranteed operating temperature range of  $0^{\circ}$ C to +75°C for DS75123, unless otherwise specified. Typicals are for  $V_{CC}$  = 5.0V,  $T_{A}$  = 25°C. Positive current is defined as current into the referenced pin.

Note 4: The output voltage and current limits are guaranteed for any appropriate combination of high and low inputs specified by the truth table for the desired output.

## **DS75124 Triple Line Receiver**

#### **General Description**

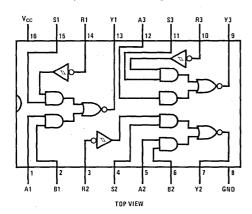
The DS75124 is designed to meet the input/output interface specifications for IBM System 360. It has built-in hysteresis on one input on each of the three receivers to provide large noise margin. The other inputs on each receiver are in a standard TTL configuration. The DS75124 is compatible with standard TTL logic and supply voltage levels.

#### **Features**

- Built-in input threshold hysteresis
- High speed . . typ propagation delay time 20 ns
- Independent channel strobes
- Input gating increases application flexibility
- Single 5.0V supply operation
- Plug-in replacement for the SN75124 and the 8T24

## **Connection Diagram and Truth Table**

Dual-In-Line Package



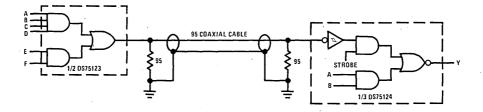
Order Number DS75124J or DS75124N See NS Package J16A or N16A

		INP	OUTPUT		
i	Α	Вţ	R	S	Υ'
i	Н	Н	X	× .	L
	X	X	Ľ	Н	L
ļ	L	Х	Н	X	∤ н
	L	X	X	L	н
ı	Х	L	н	X	н
	X	L	Х	L	Н.

H = high level, L = low level, X = irrelevant

†B input and last two lines of the truth table
are applicable to receivers 1 and 2 only.

## **Typical Application**



## **Operating Conditions**

			MIN	MAX	UNITS
Supply Voltage, VCC	7.0V	Supply Voltage, VCC	4.75	5.25	· V
Input Voltage		High Level Output Current,		-800	μΑ
R Input with VCC Applied	7.0V	Тон			
R Input with VCC not Applied	6.0V	Low Level Output Current,		16	mA
A, B, or S Input	5.5V	loL			
Output Voltage	7.0V	Operating Temperature, TA	0	+75	°C
Output Current	±100 mA				
Maximum Power Dissipation* at 25°C					
Cavity Package	1433 mW				
Molded Package	1362 mW				
Operating Temperature Range	0°C to +75°C	the second second			
Storage Temperature Range	-65°C to +150°C	i			
Lead Temperature (Soldering, 10 seconds)	300°C				
*Derate cavity package 9.6 mW/°C above	25° C: derate molded				
package 10.9 mW/° C above 25° C.	20 0, 25.215 11101000	A Committee of the Comm			
. •					

## Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	High Level Input Voltage	A, B, or S	2.0			V
		R	1.7			V
VIL	Low Level Input Voltage	A, B, or S			0.8	V
	·	R			0.7	V
V <sub>T+</sub> -V <sub>T-</sub>	Hysteresis	$V_{CC} = 5.0V, T_A = 25^{\circ}C, R, (Note 6)$	0.2	0.4		V
V <sub>I</sub>	Input Clamp Voltage	V <sub>CC</sub> = 5.0V, I <sub>1</sub> = -12 mA, A, B, or S			-1.5	٧.
I <sub>1</sub>	Input Current at Maximum	V <sub>CC</sub> = 5.25V, V <sub>IN</sub> = 5.5V, A, B, or S			1	mA
	Input Voltage	R V <sub>1</sub> = 7.0V			5.0	mA
	<b>_</b>	$V_1 = 6.0V, V_{CC} = 0$			5.0	mA
V <sub>OH</sub>	High Level Output Voltage	$V_{IH} = V_{IHMIN}$ , $V_{IL} = V_{ILMAX}$ , $I_{OH} = -800\mu A$ , (Note 4)	2.6			· V .
VoL	Low Level Output Voltage	$V_{IH} = V_{INMIN}$ , $V_{IL} = V_{ILMAX}$ , $I_{OL} = 16$ mA, (Note 4)			0.4	V
I <sub>IH</sub>	High Level Input Current	V <sub>1</sub> = 4.5V, A, B, or S	[		40	μΑ
		V <sub>I</sub> = 3.11V, R			170	μΑ
I <sub>IL</sub>	Low Level Input Current	V <sub>I</sub> = 0.4V, A, B, or S	-0.1		-1.6	mA
los	Short Circuit Output Current	$V_{CC} = 5.0V$ , $T_A = 25^{\circ}C$ , (Note 5)	-50		-100	mA
Icc	Supply Current	V <sub>CC</sub> = 5.25V	F		72	mA

## Switching Characteristics TA = 25°C, nominal power supplies unless otherwise noted

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High Level Output from R Input	(See ac Test Circuit and Switching Time Waveforms)		20	30	ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low Level Output from R Input	(See ac Test Circuit and Switching Time Waveforms)		20	30	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: All currents into device pins are shown as positive, currents out of device pins shown as negative, all voltage values are referenced with respect to network ground terminal, unless otherwise noted. All values shown as max or min on absolute value basis.

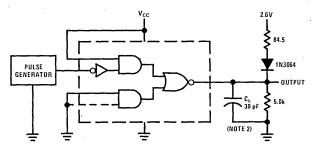
Note 3: Min/max limits apply across the guaranteed operating temperature range of 0°C to +75°C for DS75124, unless otherwise specified. Typicals are for VCC = 5.0V, TA = 25°C. Positive current is defined as current into the referenced pin.

Note 4: The output voltage and current limits are guaranteed for any appropriate combination of high and low inputs specified by the truth table for the desired output.

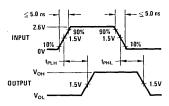
Note 5: Not more than one output should be shorted at a time.

Note 6: Hysteresis is the difference between the positive going input threshold voltage, V<sub>T+</sub>, and the negative going input threshold voltage, V<sub>T-</sub>

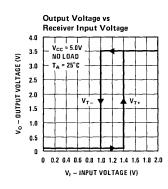
## **AC Test Circuit and Switching Time Waveforms**



Note 1: THE PULSE GENERATOR HAS THE FOLLOWING CHARACTERISTICS:  $Z_{OUT}\approx 50!2$ ,  $t_W$  = 200 ns, DUTY CYCLE = 50%. Note 2: C<sub>L</sub> INCLUDES PROBE AND JIG CAPACITANCE.



# **Typical Performance Characteristics**



# DS75125, DS75127 Seven-Channel Line Receivers

#### **General Description**

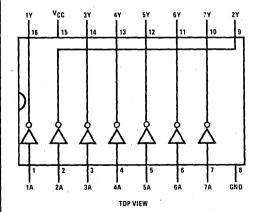
The DS75125 and DS75127 are monolithic seven-channel line receivers designed to satisfy the requirements of the IBM System 360/370 input/output interface specifications. Special low-power design and Schottky clamped transistors allow for low supply current requirements while maintaining fast switching speeds and high current TTL outputs. The DS75125 and DS75127 are characterized for operation from 0 °C to 70 °C.

#### **Features**

- Meets IBM 360/370 I/O specification
- Input resistance 7 kΩ to 20 kΩ
- Output compatible with TTL
- Schottky-clamped transistors
- Operates from single 5V supply
- High speed low propagation delay
- Ratio specification for propagation delay time, low-tohigh/high-to-low
- Seven channels in one 16-pin package
- Standard V<sub>CC</sub> and ground positioning on DS75127

### **Connection Diagrams**

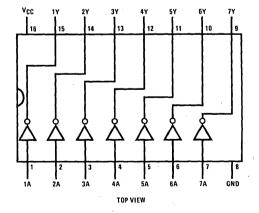
DS75125 Dual-In-Line Package



logic: Y = A

Order Number DS75125J or DS75125N See NS Package J16A or N16A

DS75127 Dual-In-Line Package



logic:Y=A

Order Number DS75127J or DS75127N See NS Package J16A or N16A

Lead Temperature (Soldering, 10 seconds)

11.9 mW/°C above 25°C.

Supply Voltage, V <sub>CC</sub> (Note 1)	7V
Input Voltage Range DS75125 DS75127	- 0.15V to 7V - 2V to 7V
Maximum Power Dissipation* at 25°C Cavity Package	1509 mW
Molded Package	1476 mW
Operating Free-Air Temperature Range	0°C to 70°C
Storage Temperature Range	- 65°C to 150°C

\*Derate cavity package 10.1 mW/°C above 25°C; derate molded package

## **Recommended Operating Conditions**

	Min	Тур	Max	Units
Supply Voltage, V <sub>CC</sub>	4.5	5	5.5	٧
High-Level Output Current, IOH			-0.4	mΑ
Low-Level Output Current, IOL			16	mΑ
Operating Free-Air Temperature, $T_A$	0		70	°C

# Electrical Characteristics over recommended operating free-air temperature range (Note 3)

300°C

Parameter	Conditions	Min	Typ (Note 5)	Max	Units
V <sub>IH</sub> High-Level Input Voltage		1.7			٧
V <sub>IL</sub> Low-Level Input Voltage				0.7	٧
V <sub>OH</sub> High-Level Output Voltage	$V_{CC} = 4.5V$ , $V_{IL} = 0.7V$ , $I_{OH} = -0.4$ mA	2.4	3.1		٧
V <sub>OL</sub> Low-Level Output Voltage	V <sub>CC</sub> = 4.5V, V <sub>IH</sub> = 1.7V, I <sub>OL</sub> = 16 mA		Ó.4	0.5	٧
I <sub>IH</sub> High-Level Input Current	V <sub>CC</sub> = 5.5V, V <sub>I</sub> = 3.11V		0.3	0.42	mA
I <sub>IL</sub> Low-Level Input Current	$V_{CC} = 5.5V, V_1 = 0.15V$			- 0.24	mA
I <sub>OS</sub> Short-Circuit Output Current (Note 4)	$V_{CC} = 5.5V, V_{O} = 0$	- 18		- 60	mA
r <sub>1</sub> Input Resistance	$V_{CC} = 4.5V$ , 0V, or Open, $\Delta V_1 = 0.15V$ to 4.15V	7		20	kΩ
I <sub>CC</sub> Supply Current	$V_{CC} = 5.5V$ , $I_{OH} = -0.4$ mA, All Inputs at 0.7V		15	25	mA
	$V_{CC} = 5.5V$ , $I_{OL} = 16$ mA, All Inputs at 4V		28	47	mA

## Switching Characteristics $V_{CC} = 5V$ , $T_A = 25$ °C

Parameter	Conditions	Min	Тур	Max	Units
t <sub>PLH</sub> Propagation Delay Time, Low-to-High-Level Output		7	14	25	ns
t <sub>PHL</sub> Propagation Delay Time, High-to-Low-Level Output	·	10	18	30	ns
† <sub>РLН</sub> Ratio of Propagation Delay Times t <sub>РНL</sub>	$R_L = 400\Omega$ , $C_L = 50$ pF, See <i>Figure 1</i>	0.5	0.8	1.3	ns
t <sub>TLH</sub> Transition Time, Low-to-High-Level Output		1	7	12	ns
t <sub>THL</sub> Transition Time, High-to-Low-Level Output		1	3	12	· ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

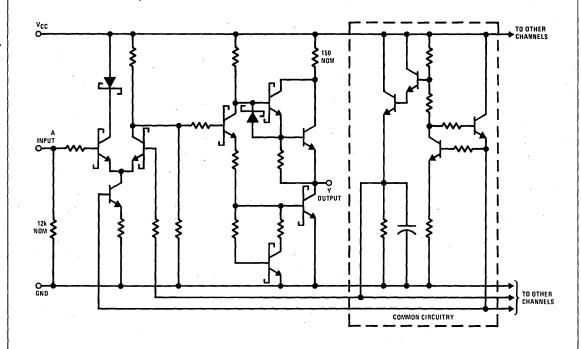
Note 2: For operation above 25°C free-air temperature, refer to Thermal Ratings for ICs in Section 12 of Interface Databook.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

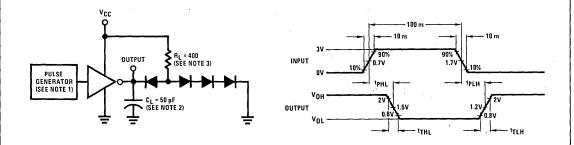
Note 4: Only one output should be shorted at a time.

Note 5: All typical values are at  $V_{CC} = 5V$ ,  $T_A = 25$ °C.

## Schematic (each receiver)



## AC Test Circuit and Switching Time Waveforms



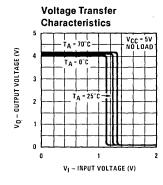
Note 1: The pulse generator has the following characteristics:  $Z_{OUT} \approx 50\Omega$ , PRR = 5 MHz.

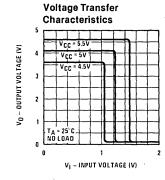
Note 2:  $C_L$  includes probe and jig capacitance.

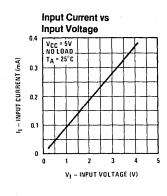
Note 3: All diodes are 1N3064 or equivalent.

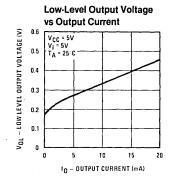
FIGURE 1

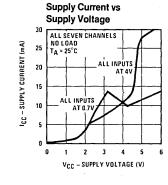
## **Typical Performance Characteristics**













# DS75128, DS75129 Eight-Channel Line Receivers

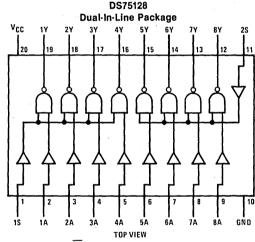
## **General Description**

The DS75128 and DS75129 are eight-channel line receivers designed to satisfy the requirements of the input-output interface specification for IBM 360/370. Both devices feature common strobes for each group of four receivers. The DS75128 has an active-high strobe; the DS75129 has an active-low strobe. Special low-power design and Schottky-diode-clamped transistors allow low supply-current requirements while maintaining fast switching speeds and high-current TTL outputs. The DS75128 and DS75129 are characterized for operation from 0 °C to 70 °C.

#### **Features**

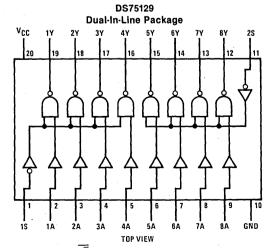
- Meets IBM 360/370 I/O specification
- Input resistance 7 kΩ to 20 kΩ
- Output compatible with TTL
- Schottky-clamped transistors
- Operates from a single 5V supply
- High speed low propagation delay
- Ratio specification t<sub>PLH</sub>/t<sub>PHL</sub>
- Common strobe for each group of four receivers
- DS75128 strobe active-high DS75129 strobe active-low

## **Connection Diagrams**



Order Number DS75128J or DS75128N See NS Package J20A or N20A

positive logic: Y = AS



Order Number DS75129J or DS75129N See NS Package J20A or N20A

# Absolute Maximum Ratings over operating free-air temperature range (unless otherwise noted)

Supply Voltage, V <sub>CC</sub> (Note 1)	7V
A Input Voltage Range	- 0.15V to 7V
Strobe Input Voltage	7V
Maximum Power Dissipation* at 25°C	
Cavity Package	1564 mW
Molded Package	1687 mW
Operating Free-Air Temperature Range	0°C to 70°C
Storage Temperature Range	- 65 °C to 150 °C
Lead Temperature	300°C
1/16 inch from Case for 60 Seconds: J Package	
Lead Temperature	260°C
1/16 Inch from Case for 10 Seconds: N Package	

<sup>\*</sup>Derate cavity package 10.4 mW/°C above 25°C; derate molded package 13.5 mW/°C above 25°C.

## **Recommended Operating Conditions**

	Will	Iур	Max	Units
Supply Voltage, V <sub>CC</sub>	4.5	5.0	5.5	٧
High-Level Output Current, I <sub>OH</sub>			- 0.4	mA
Low-Level Output Current, IOL			16	mA
Operating Free-Air Temperature, T <sub>A</sub>	0		70	°C

#### Electrical Characteristics over recommended operating free-air temperature range (Note 3)

Parameter				Conditions		Typ (Note 5)	Max	Units	
Α Α		AS		1.7			v		
V IH	High-Level Input Vo	maye	S					L ·	
VII	Low-Level Input Vo	ltago	Α				0.7	V	
			s				0.7	<u> </u>	
V <sub>OH</sub>	High-Level Output	Voitage	!	$V_{CC} = 4.5V$ , $V_{IL} = 0.7V$ , $I_{OH} = -0.4$ mA	2.4	3.1		V	
V <sub>OL</sub> Low-Level Output Voltage			$V_{CC} = 4.5V$ , $V_{IH} = 1.7V$ , $I_{OL} = 16$ mA		0.4	0.5	٧		
Vı	V <sub>I</sub> Input Clamp Voltage S		s	$V_{CC} = 4.5V, I_{I} = -18 \text{ mA}$			- 1.5	V	
		Α	$V_{CC} = 5.5V, V_1 = 3.11V$		0.3	0.42	mA		
		S	$V_{CC} = 5.5V, V_{I} = 2.7V$			20	μĀ		
		Α	$V_{CC} = 5.5V, V_1 = 0.15V$			0.24	mA		
		S	$V_{CC} = 5.5V, V_1 = 0.4V$		- 0.		] IIIA		
I <sub>OS</sub> Short-Circuit Output Current		ent	$V_{CC} = 5.5V, V_{O} = 0$	- 18		- 60	mA		
(Note 4)									
rl	r <sub>I</sub> Input Resistance			$V_{CC} = 4.5V$ , 0V, or Open, $\Delta V_1 = 0.15V$ to 4.15V	7		20	kΩ	
-	DS75		28	V <sub>CC</sub> = 5.5V, Strobe at 2.4V, All A Inputs at 0.7V		19	31		
Icc	Supply Current	DS751	29	V <sub>CC</sub> = 5.5V, Strobe at 0.4V, All A Inputs at 0.7V		19	31	mA	
'CC				V <sub>CC</sub> =5.5V, Strobe at 2.4V, All A Inputs at 4V		32	53	] '''^	
	DS7512		29	V <sub>CC</sub> = 5.5V, Strobe at 0.4V, All A Inputs at 4V	<b>!</b>	32	53	L	

## Switching Characteristics $V_{CC} = 5V$ , $T_A = 25$ °C

Parameter		0		S751	28					
rarameter			Conditions	Min	Тур	Max	Min	Тур	Max	Units
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High-Level Output	^		7	14	25	7	14	25	ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low-Level Output	^	B 4000	10	18	30	10	18	30	ns
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High-Level Output	٥	$R_L = 400\Omega$ ,		26 .	40		20	35	ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low-Level Output	3	C = 50 pF		22	35		16	30	ns
t <sub>PLH</sub>	Ratio of Propagation Delay Times	Α	C <sub>L</sub> = 50 pF,	0.5	0.8	1.3	0.5	0.8	1.3	
t <sub>TLH</sub>	Transition Time, Low-to-High-Level Output	See Figure 1	1	7	12	1	7	12	ns	
t <sub>THL</sub> Transition Time, High-to-Low-Level output				1	3	12	1	3	12	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

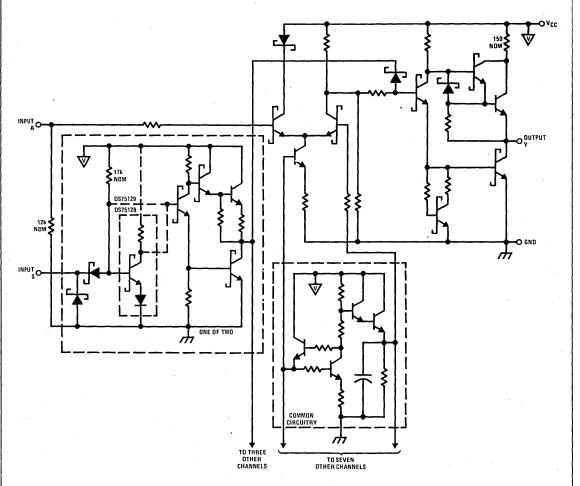
Note 2: For operation above 25 °C free-air temperature, refer to Thermal Ratings for ICs, Section 12, Interface Databook.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

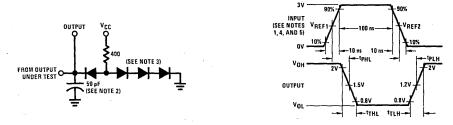
Note 4: Only one output should be shorted at a time.

Note 5: All typical values are at  $V_{CC} = 5V$ ,  $T_A = 25$  °C.

## Schematic Diagram (each receiver)



## **AC Test Circuit and Switching Time Waveforms**

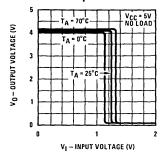


- Note 1: Input pulses are supplied by a generator having the following characteristics:  $Z_0 = 50\Omega$ , PRR = 5 MHz.
- Note 2: Includes probe and jig capacitance.
- Note 3: All diodes are 1N3064 or equivalent.
- Note 4: The strobe inputs of DS75129 are in-phase with the output.
- Note 5:  $V_{REF1} = 0.7V$  and  $V_{REF2} = 1.7V$  for testing data (A) inputs,  $V_{REF1} = V_{REF2} = 1.3V$  for strobe inputs.

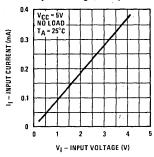
FIGURE 1

## **Typical Characteristics**

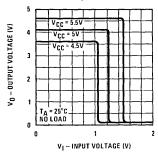
#### Voltage Transfer Characteristics From A Inputs



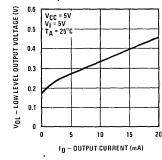
#### Input Current vs Input Voltage, A Inputs



# Voltage Transfer Characteristics From A Inputs



#### Low-Level Output Voltage vs Output Current





# **DS75150 Dual Line Driver** General Description

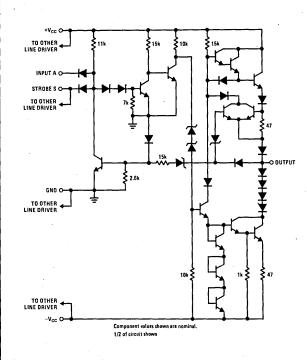
The DS75150 is a dual monolithic line driver designed to satisfy the requirements of the standard interface between data terminal equipment and data communication equipment as defined by EIA Standard RS-232-C. A rate of 20,000 bits per second can be transmitted with a full 2500 pF load. Other applications are in data-transmission systems using relatively short single lines, in level translators, and for driving MOS devices. The logic input is compatible with most TTL and LS families. Operation is from -12V and +12V power supplies.

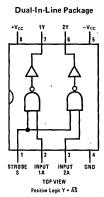
#### **Features**

- Withstands sustained output short-circuit to any low impedance voltage between -25V and +25V
- 2µs max transition time through the -3V to +3V transition region under full 2500 pF load
- Inputs compatible with most TTL and LS families
- Common strobe input
- Inverting output
- Slew rate can be controlled with an external capacitor at the output
- Standard supply voltages

±12V

## **Schematic and Connection Diagrams**





Order Number DS75150J-8 or DS75150N See NS Package J08A or N08A

			MIN	MAX	UNITS
Supply Voltage +VCC	15V	Supply Voltage (+VCC)	10.8	13.2	V
Supply Voltage -VCC	-15V	Supply Voltage (-VCC)	-10.8	-13.2	V
Input Voltage	15V	Input Voltage (V <sub>I</sub> )	0	+5.5	V
Applied Output Voltage Storage Temperature Range	±25V -65°C to +150°C	Output Voltage (VO)		±15	V
Maximum Power Dissipation* at 25°C	1133 mW	Operating Ambient Temperature	0	+70	°C
Cavity Package Molded Package	1133 mW 1022 mW	Range (T <sub>A</sub> )			
Lead Temperature (Soldering, 10 seconds)	300° C				

**Operating Conditions** 

#### DC Electrical Characteristics (Notes 2, 3, 4 and 5)

Absolute Maximum Ratings (Note 1)

\*Derate cavity package 7.6 mW/°C above 25°C; derate molded

package 8.2 mW/°C above 25°C.

	PARAMETER	CONDITIO	ONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	High-Level Input Voltage	(Figure 1)		2			٧
V <sub>1L</sub>	Low-Level Input Voltage	(Figure 2)				0.8	٧
V <sub>он</sub>	High-Level Output Voltage	$+V_{CC} = 10.8V, -V_{CC} = -13.2V$ R <sub>L</sub> = 3 kΩ to 7 kΩ, (Figure 2)	$+V_{CC}$ = 10.8V, $-V_{CC}$ = -13.2V, $V_{IL}$ = 0.8V, $R_L$ = 3 kΩ to 7 kΩ, (Figure 2)				V
V <sub>OL</sub>	Low-Level Output Voltage	$+V_{CC} = 10.8V, -V_{CC} = -10.8V$ $R_L = 3 k\Omega$ to 7 k $\Omega$ , (Figure 1)	/, V <sub>IH</sub> = 2V,		-8	-5	V
l <sub>iH</sub>	High-Level Input Current	$+V_{CC} = 13.2V, -V_{CC} = -13.2V,$ Data Input $V_1 = 2.4V, (Figure 3)$ $+V_{CC} = 13.2V, -V_{CC} = -13.2V,$ Strobe Input $V_1 = 2.4V, (Figure 3)$			1	10	μΑ
					2	20	μΑ
1 <sub>IL</sub>	Low-Level Input Current	+V <sub>CC</sub> = 13.2V, -V <sub>CC</sub> = -13.2V, V <sub>I</sub> = 0.4V, (Figure 3)	Data Input		-1	-1.6	mA
		+V <sub>CC</sub> = 13.2V, -V <sub>CC</sub> = -13.2V, V <sub>1</sub> = 0.4V, (Figure 3)	Strobe Input		-2	-3.2	mA
los	Short-Circuit Output Current	+V <sub>CC</sub> = 13.2V, -V <sub>CC</sub> = -13.2V,	V <sub>O</sub> = 25V V <sub>O</sub> = -25V		2	5	mA
	· · · · · · · · · · · · · · · · · · ·	(Figure 4), Note 4	V <sub>O</sub> = -25V		-3	-6	mA
		(Figure 4), Note 4	$V_O = 0V$ , $V_I = 3V$		15	30	mΑ
		·	$V_0 = 0V, V_1 = 0V$		-15	-30	mA
<sup>+l</sup> ccн	Supply Current From +V <sub>CC</sub> , High-Level Output	$+V_{CC} = 13.2V, -V_{CC} = -13.2V$ $R_L = 3 \text{ k}\Omega, T_A = 25^{\circ}\text{C}, (Figure$			10	22	mA
-Іссн	Supply Current From -V <sub>CC</sub> , High-Level Output	$+V_{CC} = 13.2V, -V_{CC} = -13.2V, V_1 = 0V,$ $R_L = 3 kΩ, T_A = 25^{\circ}C, (Figure 5)$			-1	-10	mA
+I <sub>CCL</sub>	Supply Current From +V <sub>CC</sub> , Low-Level Output	$+V_{CC} = 13.2V, -V_{CC} = -13.2V$ $R_L = 3 k\Omega, T_A = 25^{\circ}C, (Figur$		8	17	mA	
-I <sub>CCL</sub>	Supply Current From -V <sub>CC</sub> , Low-Level Output	$+V_{CC} = 13.2V, -V_{CC} = -13.2V$ $R_L = 3 k\Omega, T_A = 25^{\circ}C, (Figure$			-9	-20	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range for the DS75150. All typical values are for  $T_A = 25$ °C and  $+V_{CC} = 12V$ ,  $-V_{CC} = -12V$ .

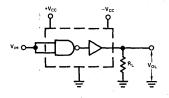
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: The algebraic convention where the most-positive (least-negative) limit is designated as maximum is used in this data sheet for logic levels only, e.g., when -5V is the maximum, the typical value is a more-negative voltage.

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>TLH</sub>	Transition Time, Low-to-High Level Output	$C_L = 2500 \text{ pF}, R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega,$ (Figure 6)	0.2	1.4	2	μs
t <sub>THL</sub>	Transition Time, High-to-Low Level Output	$C_L$ = 2500 pF, $R_L$ = 3 k $\Omega$ to 7 k $\Omega$ , (Figure 6)	0.2	1.5	2	μs
t <sub>TLH</sub>	Transition Time, Low-to-High Level Output	$C_L = 15 pF, R_L = 7 k\Omega$ , (Figure 6)		40		ns
t <sub>THL</sub>	Transition Time, High-to-Low Level Output	$C_L = 15 \text{ pF}, R_L = 7 \text{ k}\Omega$ , (Figure 6)		20		ns
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High Level Output	$C_L = 15 \text{ pF}, R_L = 7 \text{ k}\Omega$ , (Figure 6)		60		ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low Level Output	$C_L = 15 \text{ pF}, R_L = 7 \text{ k}\Omega$ , (Figure 6)		45		ns

## **DC Test Circuits**



3V VIL VOH

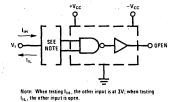


FIGURE 1. VIH, VOL

FIGURE 2. VIL, VOH

FIGURE 3. IJH, IJL

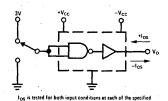


FIGURE 4. IOS

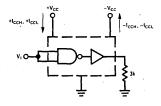
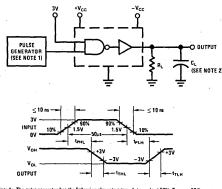


FIGURE 5. ICCH+, ICCH-, ICCL+, ICCL-

## AC Test Circuit and Switching Time Waveforms



Note 1: The pulse generator has the following characteristics: duty cycle  $\leq$  50%,  $Z_{OUT} \approx 50\Omega$ .

#### FIGURE 6.

## **Typical Performance Characteristics**

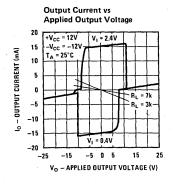


FIGURE 7.

#### **DS75154 Quad Line Receiver**

#### **General Description**

The DS75154 is a quad monolithic line receiver designed to satisfy the requirements of the standard interface between data terminal equipment and data communication equipment as defined by EIA Standard RS-232C. Other applications are in relatively short, single-line, point-to-point data transmission systems and for level translators. Operation is normally from a single 5V supply; however, a built-in option allows operation from a 12V supply without the use of additional components. The output is compatible with most TTL and LS circuits when either supply voltage is used.

In normal operation, the threshold-control terminals are connected to the  $V_{\rm CC1}$  terminal, pin 15, even if power is being supplied via the alternate  $V_{\rm CC2}$  terminal, pin 16. This provides a wide hysteresis loop which is the difference between the positive-going and negative-going threshold voltages. In this mode, if the input voltage goes to zero, the output voltage will remain at the low or high level as determined by the previous input.

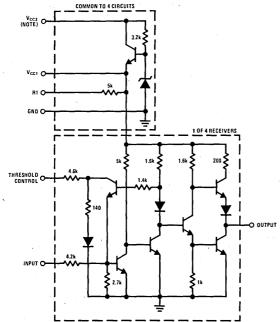
For fail-safe operation, the threshold-control terminals are open. This reduces the hysteresis loop by causing

the negative-going threshold voltage to be above zero. The positive-going threshold voltage remains above zero as it is unaffected by the disposition of the threshold terminals. In the fail-safe mode, if the input voltage goes to zero or an open-circuit condition, the output will go to the high level regardless of the previous input condition.

#### **Features**

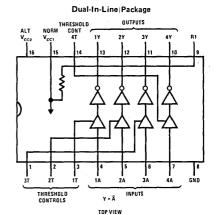
- Input resistance, 3 k $\Omega$  to 7 k $\Omega$  over full RS-232C voltage range
- Input threshold adjustable to meet "fail-safe" requirements without using external components
- Inverting output compatible with TTL or LS
- Built-in hysteresis for increased noise immunity
- Output with active pull-up for symmetrical switching speeds
- Standard supply voltage—5V or 12V

#### **Schematic and Connection Diagrams**



Note: When using  $V_{CC1}$  (pin 15),  $V_{CC2}$  (pin 16) may be left open or shorted to  $V_{CC1}$ . When using  $V_{CC2}$ ,  $V_{CC1}$  must be left open or connected to the threshold control pins.

See NS Package J16A or N16A



Order Number DS75154J or DS75154N

#### Absolute Maximum Ratings (Note 1)

Normal Supply Voltage (Pin 15),(V<sub>CC1</sub>) Alternate Supply Voltage (Pin 16),(V<sub>CC2</sub>)

Input Voltage

Storage Temperature Range

7V 14V ±25V –65°C to +150°C

Maximum Power Dissipation\* at 25°C

Cavity Package 1433 mW

Molded Package 1362 mW

Lead Temperature (Soldering, 10 seconds) 300°C

\*Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.9 mW/°C above 25°C.

## **Operating Conditions**

	MIN	MAX	UNITS
Supply Voltage (Pin 15),(V <sub>CC1</sub> )	4.5	5.5	V
Alternate Supply Voltage (Pin 16) (V <sub>CC2</sub> )	10.8	13.2	, <b>V</b>
Input Voltage		±15	V
Temperature, (T <sub>A</sub> )	0	+70	°C

#### Electrical Characteristics (Notes 2, 3 and 4)

PARAMETER		Ç	CONDITIONS		N TYP	MAX	UNITS				
ViH	High-Level Input Voltage	(Figure 1)		3			٧				
V <sub>IL</sub>	Low-Level Input Voltage	(Figure 1)				-3	V				
V <sub>T+</sub>	Positive-Going Threshold Voltage	/5: 41	Normal Operation	0.8	2.2	3 .	V				
		(Figure 1)	Fail-Safe Operation	0.8	2.2	3	V				
V <sub>T</sub>	V <sub>T</sub> _ Negative-Going Threshold Voltage	(5:	Normal Operation	-3	-1.1	0	V				
		(Figure 1)	Fail-Safe Operation	0.8	1.4	3	V				
V <sub>T+</sub> -V <sub>T-</sub>	Hysteresis	(Fin - 4)	Normal Operation	0.8	3.3	6	V				
		(Figure 1)	Fail-Safe Operation	0	0.8	2.2	V				
V <sub>OH</sub>	High-Level Output Voltage	$I_{OH} = -400\mu A$ , (Figure 1)		2.4	3.5		V				
VoL	Low-Level Output Voltage	I <sub>OL</sub> = 16 m/	A, (Figure 1)		0.23	0.4	V				
rı	Input Resistance	1	$\Delta V_1 = -25V$ to $-14V$	3	5	7	kΩ				
	•	1					$\Delta V_1 = -14V$ to $-3V$	3	5	7	kΩ
		(Figure 2)	$\Delta V_1 = -3V \text{ to } +3V$	3	6		kΩ				
			$\Delta V_1 = 3V$ to 14V	3	5	7	kΩ				
			$\Delta V_1 = 14V$ to 25V	3	5	7	kΩ				
V <sub>I(OPEN)</sub>	Open-Circuit Input Voltage	1, = 0, (Figu	ure 3)	0	0.2	2	. V				
los	Short-Circuit Output Current (Note 5)	V <sub>CC1</sub> = 5.5V, V <sub>1</sub> = -5V, (Figure 4)		-10	-20	-40	mA				
I <sub>CC1</sub>	Supply Current From V <sub>CC1</sub>	V <sub>CC1</sub> = 5.5\	$V_A = 25^{\circ}C$ , (Figure 5)		20	35	mA				
I <sub>CC2</sub>	Supply Current From V <sub>CC2</sub>	V <sub>CC2</sub> = 13.2	2V, T <sub>A</sub> = 25°C, (Figure 5)		23	40	m.A				

## Switching Characteristics ( $V_{CC1} = 5V, T_A = 25^{\circ}C$ )

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High Level Output	$C_L = 50 \text{ pF}, R_L = 390\Omega, (Figure 6)$		22		ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low Level Output	$C_L = 50 \text{ pF}, R_L = 390\Omega, (Figure 6)$		20		ns
t <sub>TLH</sub>	Transition Time, Low-to-High Level Output	$C_L = 50 \text{ pF}, R_L = 390\Omega. (Figure 6)$		9		ns
t <sub>THL</sub>	Transition Time, High-to-Low Level Output	$C_L = 50 \text{ pF}, R_L = 390\Omega, (Figure 6)$		6		ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

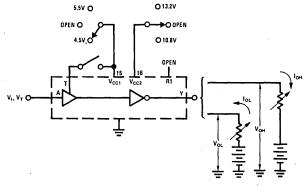
Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range for the DS75154. All typical values are for  $T_A = 25^{\circ}C$  and  $V_{CC1} = 5V$ .

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: The algebraic convention where the most-positive (least-negative) limit is designated as maximum is used in this data sheet for logic and threshold levels only, e.g., when -3V is the maximum, the minimum limit is a more-negative voltage.

Note 5: Only one output at a time should be shorted.

## **DC Test Circuits and Truth Tables**

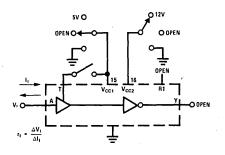


TEST	MEASURE	A	Т	Υ	V <sub>CC1</sub> (PIN 15)	V <sub>CC2</sub> (PIN 16)
Open-Circuit Input	V <sub>он</sub>	Open	Open	I <sub>ОН</sub>	4.5V	Open
(fail-safe)	V <sub>он</sub>	Open	Open		Open	10.8V
V <sub>T+</sub> min,	V <sub>он</sub>	0.8V	Open	I <sub>ОН</sub>	5.5V	Open
V <sub>T+</sub> (fail-safe)	V <sub>он</sub>	0.8V	Open		Open	13.2V
V <sub>T+</sub> min (Normal)	V <sub>он</sub>	Note 1	Pin 15	I <sub>ОН</sub>	5.5V and T	Open
	V <sub>он</sub>	Note 1	Pin 15	I <sub>ОН</sub>	T	13.2V
V <sub>IL</sub> max,	V <sub>он</sub>	-3V	Pin 15	I <sub>ОН</sub>	5.5V and T	Open
V <sub>T-</sub> min (Normal)	V <sub>он</sub>	-3V	Pin 15		T	13.2V
V <sub>IH</sub> min, V <sub>T+</sub> max, V <sub>T-</sub> max (fail-safe)	V <sub>OL</sub>	3V 3V	Open Open	l <sub>OL</sub>	4.5V Open	Open 10.8V
V <sub>IH</sub> min, V <sub>T+</sub> max	V <sub>OL</sub>	3V	Pin 15	I <sub>OL</sub>	4.5V and T	Open
(Normal)	V <sub>OL</sub>	3V	Pin 15		T	10.8V
V <sub>T</sub> _ max (Normal)	V <sub>OL</sub>	Note 2 Note 2	Pin 15 Pin 15	l <sub>ot</sub>	5.5V and T T	Open 13,2V

Note 1: Momentarily apply -5V, then 0.8V.

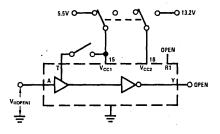
Note 2: Momentarily apply 5V, then ground.

FIGURE 1. VIH, VIL, VT+, VT-, VOH, VOL



т	V <sub>CC1</sub> (Pin 15)	V <sub>CC2</sub> (Pin 16)
Open	5V	Open
Open	Gnd	Open
Open	Open	Open
Pin 15	T and 5V	Open
Gnd	Gnd	Open
Open	Open	12V
Open	Open	Gnd
Pin 15	Т	. 12V
Pin 15	T	Gnd
Pin 15	T	Open

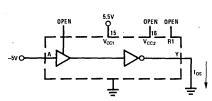
FIGURE 2. rl



т	V <sub>CC1</sub> (Pin 15)	V <sub>CC2</sub> (Pin 16)
Open	5.5V	Open
Pin 15	5.5V	Open
Open	Open	13.2V
Pin 15	T	13.2V

FIGURE 3. VI (OPEN)

## DC Test Circuits (Continued)



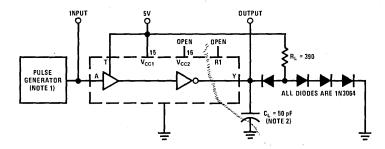
Each output is tested separately.

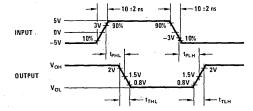
SVO All four line receivers are tested simultaneously.

FIGURE 4. IOS

FIGURE 5. ICC

#### **AC Test Circuit and Switching Time Waveforms**

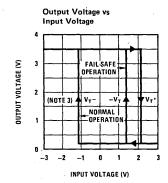




Note 1: The pulse generator has the following characteristics:  $Z_{OUT}$  =  $50\Omega$ ,  $t_W$  = 200 ns, duty cycle  $\leq 20\%$ . Note 2:  $C_L$  includes probe and jig capacitance

FIGURE 6.

## **Typical Performance Characteristics**





## DS7820/DS8820 Dual Line Receiver

## **General Description**

The DS7820, specified from -55°C to +125°C, and the DS8820, specified from 0°C to +70°C, are digital line receivers with two completely independent units fabricated on a single silicon chip. Intended for use with digital systems connected by twisted pair lines, they have a differential input designed to reject large common mode signals while responding to small differential signals. The output is directly compatible with TTL or LS integrated circuits.

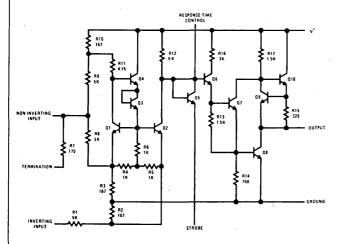
#### **Features**

- Operation from a single +5V logic supply
- Input voltage range of ±15V

- Each channel can be strobed independently
- High input resistance
- Fan out of two with TTL integrated circuits

The response time can be controlled with an external capacitor to eliminate noise spikes, and the output state is determined for open inputs. Termination resistors for the twisted pair line are also included in the circuit. Both the DS7820 and the DS8820 are specified, worst case, over their full operating temperature range, for  $\pm 10\text{-percent}$  supply voltage variations and over the entire input voltage range.

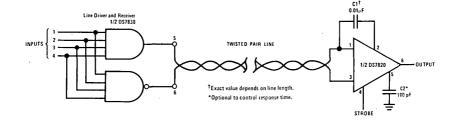
## **Schematic and Connection Diagrams**



# Dual-In-Line Package INPUT 1 14 V.c. ITERMINATION 2 13 INPUT 12 TERMINATION 11 INPUT 15 TERMINATION 11 INPUT 10 STROBE 1 IN E 10 STROBE 1 IN

Order Number DS7820J, DS8820J or DS8820N See NS Package J14A or N14A

## **Typical Application**



Absolute Maximum Ratings (Note 1)		Operating Conditions					
			MIN	MAX	UNITS		
Supply Voltage	8.0V	Supply Voltage (V <sub>CC</sub> )					
Input Voltage	±20V	DS7820	4.5	5.5	V		
Differential Input Voltage	±20V	DS8820	4.75	5.25	V		
Strobe Voltage	8.0∨	Temperature (T <sub>A</sub> )					
Output Sink Current	25 mA	DS7820	<b>-</b> 55	+125	°c		
Maximum Power Dissipation* at 25°C		DS8820	Ō	+70	°c		
Cavity Package	1308 mW						
Molded Package	1207 mW						
Storage Temperature Range	-65°C to +150°C						
Lead Temperature (Soldering, 10 sec)	300°C						
*Derate cavity package 8.7 mW/°C above package 9.7 mW/°C above 25°C.	e 25°C; derate molded						

#### Electrical Characteristics (Notes 2 and 3)

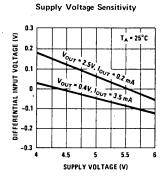
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>TH</sub>	Input Threshold Voltage	V <sub>CM</sub> = 0	-0.5	0	0.5	V
		$-15V \le V_{CM} \le 15V$	-1.0	0	1.0	V
VoH	High Output Level	I <sub>OUT</sub> ≤ 0.2 mA	2.5		5.5	V
VoL	Low Output Level	I <sub>SINK</sub> ≤ 3.5 mA	0		0.4	V
R <sub>I</sub> -	Inverting Input Resistance		3.6	5.0		kΩ
R <sub>I</sub> +	Non-Inverting Input Resistance		1.8	2.5		kΩ
R <sub>T</sub>	Line Termination Resistance	T <sub>A</sub> = 25°C	120	170	250	Ω
t <sub>r</sub>	Response Time	C <sub>DELAY</sub> = 0		40		ns
		C <sub>DELAY</sub> = 100 pF		150		ns
I <sub>ST</sub>	Strobe Current	V <sub>STROBE</sub> = 0.4V		-1.0	-1.4	mA
		V <sub>STROBE</sub> = 5.5V			5.0	μΑ
Icc	Power Supply Current	V <sub>IN</sub> = 15V		3.2	6.0	· mA
		V <sub>IN</sub> = 0		5.8	10.2	mA
		V <sub>IN</sub> = -15V		8.3	15.0	mA
1 <sub>IN</sub> +	Non-Inverting Input Current	V <sub>IN</sub> = 15V		5.0	7.0	mA
		V <sub>IN</sub> = 0	-1.6	-1.0		mA
		V <sub>IN</sub> = -15V	-9.8	-7.0		mΑ
I <sub>IN</sub> -	Inverting Input Current	V <sub>IN</sub> = 15V		3.0	4.2	mA
		V <sub>IN</sub> = 0		0	-0.5	mA
		V <sub>IN</sub> = -15V	-4.2	-3.0		mA

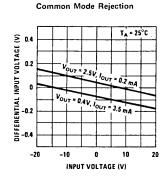
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

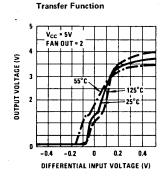
Note 2: These specifications apply for  $4.5 \text{V} \le \text{V}_{\text{CC}} \le 5.5 \text{V}$ ,  $-15 \text{V} \le \text{V}_{\text{CM}} \le 15 \text{V}$  and  $-55^{\circ}\text{C} \le \text{T}_{\text{A}} \le +125^{\circ}\text{C}$  for the DS7820 or  $0^{\circ}\text{C} \le \text{T}_{\text{A}} \le +70^{\circ}\text{C}$  for the DS8820 unless otherwise specified; typical values given are for  $\text{V}_{\text{CC}} = 5.0 \text{V}$ ,  $\text{T}_{\text{A}} = 25^{\circ}\text{C}$  and  $\text{V}_{\text{CM}} = 0$  unless stated differently. Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

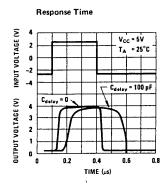
Note 4: The specifications and curves given are for one side only. Therefore, the total package dissipation and supply currents will be double the values given when both receivers are operated under identical conditions.

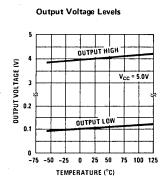
## **Typical Performance Characteristics** (Note 3)

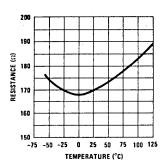




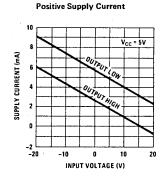


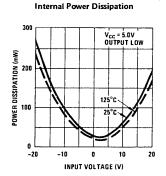






**Termination Resistance** 







## DS7820A/DS8820A Dual Line Receiver

#### **General Description**

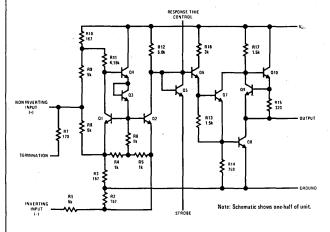
The DS7820A and the DS8820A are improved performance digital line receivers with two completely independent units fabricated on a single silicon chip. Intended for use with digital systems connected by twisted pair lines, they have a differential input designed to reject large common mode signals while responding to small differential signals. The output is directly compatible with TTL or LS integrated circuits. Some important design features include:

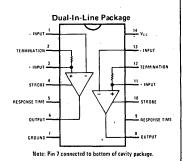
- Operation from a single +5V logic supply
- Input voltage range of ±15V
- Strobe low forces output to "1" state
- High input resistance

- Fanout of ten with TTL integrated circuits
- Outputs can be wire OR'ed
- Series 54/74 compatible

The response time can be controlled with an external capacitor to reject input noise spikes. The output state is a logic "1" for both inputs open. Termination resistors for the twisted pair line are also included in the circuit. Both the DS7820A and the DS8820A are specified, worst case, over their full operating temperature range (–55°C to 125°C and 0°C to 70°C respectively), over the entire input voltage range, for  $\pm 10\%$  supply voltage variations.

## **Schematic and Connection Diagrams**

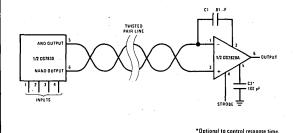




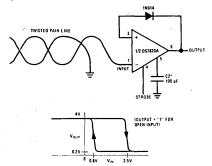
Order Number DS7820AJ, DS8820AJ or DS8820AN See NS Package J14A or N14A

## **Typical Applications**

Differential Line Driver and Receiver



#### Single Ended (EIA-RS232C) Receiver with Hysteresis



Absolute Maximum Ratings (Note 1)		Operating Condi	tions		
			MIN	MAX	UNITS
Supply Voltage	8.0V	Supply Voltage (V <sub>CC</sub> )			
Common-Mode Voltage	±20V	DS7820A	4.5	5.5	V
Differential Input Voltage	±20V	DS8820A	4.75	5.25	V
Strobe Voltage	8.0V	Temperature (T <sub>A</sub> )			
Output Sink Current	50 mA	DS7820A			°c
Storage Temperature Range	-65°C to 150°C	,	-55	+125	°C
Maximum Power Dissipation* at 25°C		DS8820A	0	+70	C
Cavity Package	1308 mW				
Molded Package	1207 mW				
Lead Temperature (Soldering, 10 sec)	300°C				
*Derate cavity package 8.7 mW/°C above package 9.7 mW/°C above 25°C.	e 25°C; derate molded				

#### Electrical Characteristics (Notes 2, 3, and 4)

	PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>TH</sub>	Differential Threshold Voltage	, ···	$-3V \le V_{CM} \le +3V$		0.06	0.5	V
		I	-15V ≤ V <sub>CM</sub> ≤ +15V		0.06	1.0	V
		I <sub>OUT</sub> = +16 mA,			-0.08	−0.5	
		V <sub>OUT</sub> ≤ 0.4V	-15V ≤ V <sub>CM</sub> ≤ +15V		-0.08	-1.0	V
$R_1^-$	Inverting Input Resistance	$-15V \le V_{CM} \le +15$	V	3.6	5		kΩ
R <sub>I</sub> +	Non-Inverting Input Resistance	$-15V \le V_{CM} \le +15$	v .	1.8	2.5		kΩ
R <sub>T</sub>	Line Termination Resistance	T <sub>A</sub> = 25°C		120	170	250	Ω
1,-	Inverting Input Current	V <sub>CM</sub> = 15V			3.0	4.2	mA
		V <sub>CM</sub> = 0V			0	-0.5	mA
		V <sub>CM</sub> = -15V			-3.0	-4.2	mA ,
l <sub>i</sub> +	Non-Inverting Input Current	V <sub>CM</sub> = 15V			5.0	7.0	mA
		V <sub>CM</sub> = 0V			-1.0	-1.6	mA
		V <sub>CM</sub> = -15V			-7.0	-9.8	mA
Icc	Power Supply Current	-	$V_{DIFF} = -1V \qquad V_{CM} = 15$ $V_{CM} = -1$	5V	3.9	6.0	mA
	One Side Only	I <sub>OUT</sub> = Logical "0"	V <sub>CM</sub> = -1	15V	9.2	14.0	mA
			$V_{DIFF} = -0.5V, V_{CM} = 0V$	/	6.5	10.2	mA
VoH	Logical "1" Output Voltage	$I_{OUT} = -400\mu A, V_{D}$	<sub>IFF</sub> = 1V	2.5	4.0	5.5	V
VoL	Logical "0" Output Voltage	Ι <sub>Ουτ</sub> = +16 mA, V <sub>D</sub>	IFF = -1V	. 0	0.22	0.4	٧.
V <sub>SH</sub>	Logical "1" Strobe Input Voltage	I <sub>OUT</sub> = +16 mA, V <sub>O</sub>	$_{\rm UT} \leq 0.4$ V, $V_{\rm DIFF} = -3$ V	2.1			V
V <sub>SL</sub>	Logical "0" Strobe Input Voltage	I <sub>OUT</sub> = -400μA, V <sub>O</sub>	$_{\rm UT} \ge 2.5 \text{V}$ , $\text{V}_{\text{DIFF}} = -3 \text{V}$			0.9	V
I <sub>SH</sub>	Logical "1" Strobe Input Current	V <sub>STROBE</sub> = 5.5V, V	DIFF = 3V		0.01	5.0	μΑ
I <sub>SL</sub>	Logical "0" Strobe Input Current	V <sub>STROBE</sub> = 0.4V, V	DIFF = -3V		-1.0	-1.4	mA
I <sub>sc</sub>	Output Short Circuit Current	I <sub>OUT</sub> = 0V, V <sub>CC</sub> = 5	.5V, V <sub>STROBE</sub> = 0V	-2.8	-4.5	-6.7	mA ·

## Switching Characteristics T<sub>A</sub> = 25°C, V<sub>CC</sub> = 5V, unless otherwise noted

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd0</sub>	Propagation Delay, Differential Input to "O" Output			30	45	ns
t <sub>pd1</sub>	Propagation Delay, Differential Input to "1" Output	D = 4000 0 45 5 5 5		27	40	ns
t <sub>pd0</sub>	Propagation Delay, Strobe Input to "O" Output	$R_L = 400\Omega$ , $C_L = 15 pF$ , see Figure 1		16	25	ns
t <sub>pd1</sub>	Propagation Delay, Strobe Input to "1" Output			18	30	ns

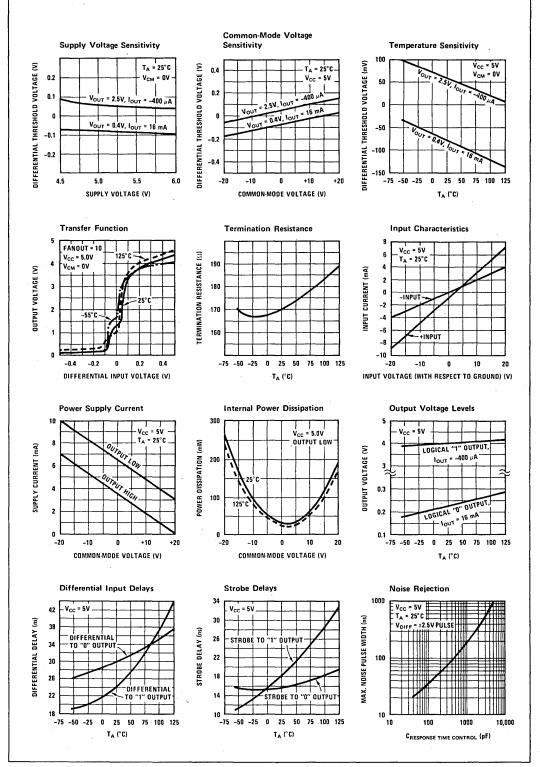
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: These specifications apply for  $4.5 \text{V} \le \text{V}_{\text{CC}} \le 5.5 \text{V}$ ,  $-15 \text{V} \le \text{V}_{\text{CM}} \le 15 \text{V}$  and  $-55^{\circ}\text{C} \le \text{T}_{\text{A}} \le +125^{\circ}\text{C}$  for the DS7820A or  $4.75 \text{V} \le \text{V}_{\text{CC}} \le 5.25 \text{V}$ ,  $0^{\circ}\text{C} \le \text{T}_{\text{A}} \le +70^{\circ}\text{C}$  for the DS8820A unless otherwise specified. Typical values given are for  $\text{V}_{\text{CC}} = 5.0 \text{V}$ ,  $\text{T}_{\text{A}} = 25^{\circ}\text{C}$  and  $\text{V}_{\text{CM}} = 0.0 \text{V}$  unless stated differently.

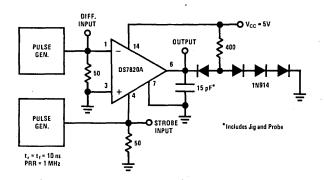
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis,

Note 4: Only one output at a time should be shorted.

#### Typical Performance Characteristics (Note 3)



## **AC Test Circuit and Waveforms**



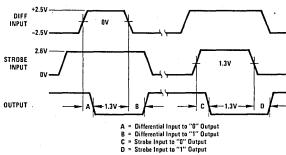


FIGURE 1



# DS78C20/DS88C20 Dual CMOS Compatible Differential Line Receiver

## **General Description**

The DS78C20 and DS88C20 are high performance, dual differential, CMOS compatible line receivers for both balanced and unbalanced digital data transmission. The inputs are compatible with EIA and Federal Standards.

Input specifications meet or exceed those of the popular DS7820/DS8820 line receiver, and the pinout is identical.

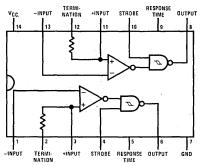
A response pin is provided for controlling sensitivity to input noise spikes with an external capacitor. Each receiver includes a  $180\Omega$  terminating resistor, which may be used optionally on twisted pair lines. The DS78C20 is specified over a  $-55^{\circ}$ C to  $+125^{\circ}$ C operating temperature range, and the DS88C20 over a  $0^{\circ}$ C to  $+70^{\circ}$ C range.

#### **Features**

- Meets requirements of EIA Standards RS-232-C RS-422 and RS-423, and Federal Standards 1020 and 1030
- Input voltage range of ±15V (differential or commonmode)
- Separate strobe input for each receiver
- 1/2 VCC strobe threshold for CMOS compatibility
- 5k typical input impedance
- 50 mV input hysteresis
- 200 mV input threshold
- Operation voltage range = 4.5V to 15V
- DS7830/DS8830 or MM78C30/MM88C30 recommended driver

#### **Connection Diagram**

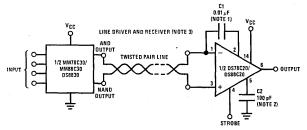
#### **Dual-In-Line Package**



Order Number DS78C20J, DS88C20J or DS88C20N See NS Package J14A or N14A

## Typical Applications

#### RS-422/RS-423 Application



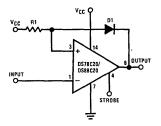
Note 1: (Optional internal termination resistor).

- a) Capacitor in series with internal line termination resistor, terminates the line and saves termination power. Exact value depends on line length.
- b) Pin 1 connected to pin 2; terminates the line.
- c) Pin 2 open; no internal line termination.
- d) Transmission line may be terminated elsewhere or not at all.

#### Note 2: Optional to control response time.

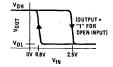
Note 3: V<sub>CC</sub> 4.5V to 15V for the DS78C20. For further information on line drivers and line receivers, refer to application notes AN-22, AN-83 and AN-108.

#### RS-232-C Application with Hysteresis



For signals which require fail-safe or have slow rise and fall times, use R1 and D1 as shown above. Otherwise, the positive input (pin 3 or 11) may be connected to ground.

Vcc	R1 ±5%
5V	4.3 kΩ
10V	<b>15 k</b> Ω
15V	<b>24</b> kΩ



#### Absolute Maximum Ratings (Note 1) **Operating Conditions** MIN MAX UNITS Supply Voltage Supply Voltage (VCC) 4.5 15 ٧ Common-Mode Voltage ±25V Temperature (TA) ±25V Differential Input Voltage DS78C20 -55 +125 °C 18V Strobe Voltage DS88C20 0 +70 °C **Output Sink Current** 50 mA Common-Mode Voltage (V<sub>CM</sub>) -15 +15 Maximum Power Dissipation\* at 25°C Cavity Package 1364 mW Molded Package 1280 mW Storage Temperature Range -65°C to +150°C

300°C

Lead Temperature (Soldering, 10 seconds)

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIO	ONS	MIN	TYP	MAX	UNITS
VTH	Differential Threshold Voltage	I <sub>OUT</sub> = -200 μA,	$-10V \le V_{CM} \le 10V$		0.06	0.2	V
		V <sub>OUT</sub> ≥ V <sub>CC</sub> - 1.2V	$-15V \le V_{CM} \le 15V$		0.06	0.3	V
		IOUT = 1.6 mA, VOUT < 0.5V	$-10V \le V_{CM} \le 10V$		-0.08	-0.2	V
		1001 - 1.6 mA, VOU1 5 0.5V	$-15V \le V_{CM} \le 15V$		-0.08	-0.3	V
RIN	Input Resistance	-15V ≤ V <sub>CM</sub> ≤ 15V			5		kΩ
RŢ	Line Termination Resistance	T <sub>A</sub> = 25°C		100	180	300	Ω
IND	Data Input Current (Unterminated)	V <sub>CM</sub> = 10V			2	3.1	mA
		V <sub>CM</sub> = 0V			0	-0.5	mA
	•	V <sub>CM</sub> = -10V			-2	-3.1	mA
Vтнв	Input Balance	I <sub>OUT</sub> = 200 μA, V <sub>OUT</sub> ≥ V <sub>CC</sub> − 1.2V, R <sub>S</sub> = 500Ω, (Note 5)	-7V ≤ V <sub>CM</sub> ≤ 7V		0.1	0.4	, V
		$I_{OUT}$ = 1.6 mA, $V_{OUT} \le 0.5V$ , $R_S$ = 500 $\Omega$ , (Note 5)	-7V ≤ V <sub>CM</sub> ≤ 7V		-0.1	-0.4	· v
Vон	Logical "1" Output Voltage	I <sub>OUT</sub> = -200 μA, V <sub>DIFF</sub> = 1V		V <sub>CC</sub> -1.2	V <sub>CC</sub> -0.75		V
VOL	Logical "0" Output Voltage	!OUT = 1.6 mA, VDIFF = -1V			0.25	0.5	V
ICC	Power Supply Current	$15V \le V_{CM} \le -15V$ ,	V <sub>CC</sub> = 5.5V	""	8	15	mA
		VDIFF = -0.5V (Both Receivers)	V <sub>CC</sub> = 15V		15	30	mA
UN(1)	Logical "1" Strobe Input Current	VSTROBE = 15V, VDIFF = 3V			15	100	μΑ
IN(0)	Logical "0" Strobe Input Current	VSTROBE = 0V, VDIFF = -3V			-0.5	-100	μА
VIH	Logical "1" Strobe Input Voltage		V <sub>CC</sub> = 5V	3.5	2.5		V
		IOUT = 1.6 mA, VOL ≤ 0.5V	V <sub>CC</sub> = 10V	8.0	5.0		V
			V <sub>CC</sub> = 15V	12.5	7.5		V
VIL	Logical "0" Strobe Input Voltage		V <sub>CC</sub> = 5V		2.5	1.5	V
		l <sub>OUT</sub> = -200 μA,	V <sub>CC</sub> = 10V		5.0	2.0	V
		V <sub>OH</sub> = V <sub>CC</sub> - 1.2V	V <sub>CC</sub> = 15V		7.5	2.5	V
los	Output Short-Circuit Current	VOUT = 0V, VCC = 15V, VSTROE	BE = 0V, (Note 4)	-5	-20	-40	mA

## Switching Characteristics $v_{CC} = 5V$ , $T_A = 25^{\circ}C$

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
tpd0(D) Differential Input to "0" Output	C <sub>L</sub> = 50 pF		60	100	ns
tpd1(D) Differential Input to "1" Output	C <sub>L</sub> = 50 pF		100	150	ns
tpdO(S) Strobe Input to "0" Output	C <sub>L</sub> = 50 pF		30	70 ,	ns
tpd1(S) Strobe Input to "1" Output	C <sub>L</sub> = 50 pF		100	150	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS78C20 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS88C20. All typical values are for  $T_A = 25^{\circ}$ C,  $V_{CC} = 5V$  and  $V_{CM} = 0V$ .

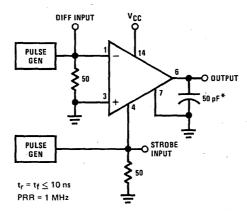
Note 3: All currents into device plns shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

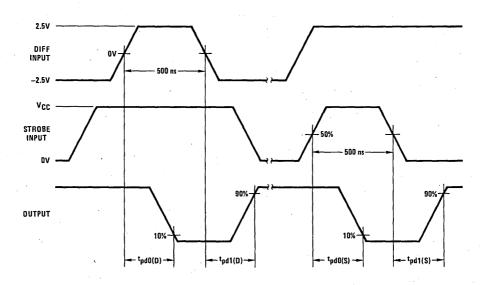
Note 5: Refer to EIA-RS-422 for exact conditions.

<sup>\*</sup>Derate cavity package 9.1 mW/°C above 25°C; derate molded package 10.2 mW/°C above 25°C.

## **AC Test Circuit and Switching Time Waveforms**



\*Includes probe and jig capacitance





## DS7830/DS8830 Dual Differential Line Driver

#### **General Description**

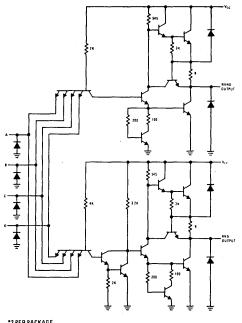
The DS7830/DS8830 is a dual differential line driver that also performs the dual four-input NAND or dual four-input AND function.

TTL (Transistor-Transistor-Logic) multiple emitter inputs allow this line driver to interface with standard TTL systems. The differential outputs are balanced and are designed to drive long lengths of coaxial cable, strip line, or twisted pair transmission lines with characteristic impedances of  $50\Omega$  to  $500\Omega$ . The differential feature of the output eliminates troublesome ground-loop errors normally associated with single-wire transmissions.

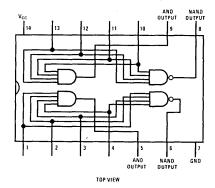
#### **Features**

- Single 5 volt power supply
- Diode protected outputs for termination of positive and negative voltage transients
- Diode protected inputs to prevent line ringing
- High speed
- Short circuit protection

## Schematic\* and Connection Diagrams



#### Dual-In-Line and Flat Package



Order Number DS7830J. DS8830J or DS8830N See NS Package J14A or N14A

\*2 PER PACKAGE.

## **Typical Application**

Digital Data Transmission 1/2 D\$7830 <sup>†</sup>Exact value depends on line length \*Optional to control response time

#### **Absolute Maximum Ratings** (Note 1) **Operating Conditions** UNITS MAX Supply Voltage (V<sub>CC</sub>) Input Voltage 5.5V DS7830 4.5 5.5 -65°C to +150°C DS8830 4.75 5.25 Storage Temperature Lead Temperature (Soldering, 10 sec) 300°C Temperature (TA) Output Short Circuit Duration (125°C) 1 second DS7830 --55 +125 °c Maximum Power Dissipation\* at 25°C DS8830 +70 Cavity Package 1308 mW Molded Package 1207 mW \*Derate cavity package 8.7 mW/°C above 25°C; derate molded package 9.7 mW/°C above 25°C.

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER	со	NDITIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	Logical "1" Input Voltage			2.0			V
VIL	Logical "0" Input Voltage					0.8	V
VoH	Logical "1" Output Voltage	V = 0.9V	I <sub>OUT</sub> = -0.8 mA	2.4			V
		V <sub>IN</sub> = 0.8V	I <sub>OUT</sub> = 40 mA	1.8	3.3		V
VoL	Logical "0" Output Voltage	V -20V	I <sub>OUT</sub> = 32 mA		0.2	0.4	V
		V <sub>IN</sub> = 2.0V	I <sub>OUT</sub> = 40 mA		0.22	0.5	٧
l <sub>iH</sub>	Logical "1" Input Current	V <sub>IN</sub> = 2.4V		j		120	μΑ
		V <sub>IN</sub> = 5.5V		)		2	mA
I <sub>IL</sub>	Logical "0" Input Current	V <sub>IN</sub> = 0.4V				-4.8	mA
I <sub>sc</sub>	Output Short Circuit Current	V <sub>CC</sub> = 5.0V,	$T_A = 125^{\circ}C$ , (Note 4)	-40	-100	-120	mA
Icc	Supply Current	V <sub>IN</sub> = 5.0V,	(Each Driver)		11	18	mA
V,	Input Clamp	V <sub>CC</sub> = Min,	I <sub>IN</sub> = -12 mA		-1.0	-1.5	V

#### **Switching Characteristics** $T_A = 25^{\circ}C$ , $V_{CC} = 5V$ , unless otherwise noted

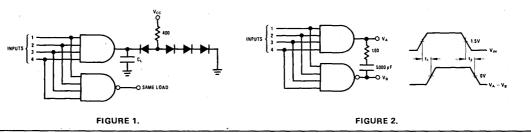
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd1</sub>	Propagation Delay AND Gate	$R_L = 400\Omega$ , $C_L = 15 pF$		8	12	ns
t <sub>pd0</sub>		(Figure 1)		11	18	ns
t <sub>pd1</sub>	Propagation Delay NAND Gate	$R_L = 400\Omega$ , $C_L = 15 pF$		8	12	ns
t <sub>pd0</sub>	•	(Figure 1)		5	8	ns
t <sub>1</sub>	Differential Delay	Load, $100\Omega$ and $5000$ pF, (Figure 2)		12	16	ns
t <sub>2</sub>	Differential Delay	Load, $100\Omega$ and $5000$ pF, (Figure 2)		12	16	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

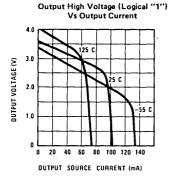
Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS7830 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8830. Typical values are for T<sub>A</sub> =  $25^{\circ}$ C and V<sub>CC</sub> = 5.0V.

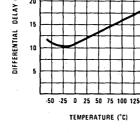
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.



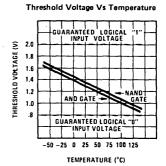
## **Typical Performance Characteristics**



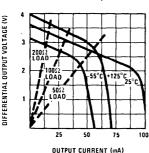


E 20

15

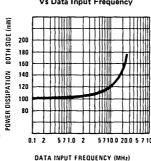


Differential Output Voltage (VAND - VNANDI) Vs Differential Output Current

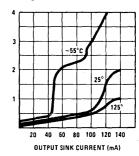


Power Dissipation (No Load) Vs Data Input Frequency

Differential Delay Vs Temperature

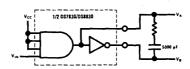


**Output Low Voltage** (Logical "0") Vs Output Current

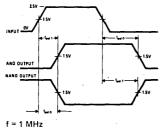


**OUTPUT VOLTAGE** 

#### **AC Test Circuit**



## **Switching Time Waveforms**



 $t_r = t_f \le 10 \text{ ns } (10\% \text{ to } 90\%)$ Duty cycle = 50%



## DS7831/DS8831, DS7832/DS8832 Dual TRI-STATE® Line Driver

#### **General Description**

Through simple logic control, the DS7831/DS8831, DS7832/DS8832 can be used as either a quad single-ended line driver or a dual differential line driver. They are specifically designed for party line (bus-organized) systems. The DS7832/DS8832 does not have the  $V_{\rm CC}$  clamp diodes found on the DS7831/DS8831.

The DS7831 and DS7832 are specified for operation over the  $-55^{\circ}$ C to  $+125^{\circ}$ C military temperature range. The DS8831 and DS8832 are specified for operation over the  $0^{\circ}$ C to  $+70^{\circ}$ C temperature range.

#### **Features**

- Series 54/74 compatible
- 17 ns propagation delay
- Very low output impedance—high drive capability
- 40 mA sink and source currents
- Gating control to allow either single-ended or differential operation
- High impedance output state which allows many outputs to be connected to a common bus line.

#### **Mode of Operation**

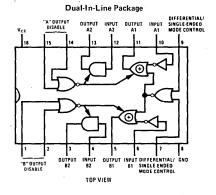
To operate as a quad single-ended line driver apply logical "0"s to the Output Disable pins (to keep the outputs in the normal low impedance mode) and apply logical "0"s to both Differential/ Single-ended Mode Control inputs. All four channels will then operate independently and no signal inversion will occur between inputs and outputs.

To operate as a dual differential line driver apply logical "0"s to the Output Disable pins and apply at least one logical "1" to the Differential/Single-ended Mode Control inputs. The inputs to the A channels should be connected together and the inputs to the B channels should be connected together.

In this mode the signals applied to the resulting inputs will pass non-inverted on the  $A_2$  and  $B_2$  outputs and inverted on the  $A_1$  and  $B_1$  outputs.

When operating in a bus-organized system with outputs tied directly to outputs of other (continued)

## **Connection and Logic Diagram**



Order Number DS7831J, DS8831J, DS7832J, DS8832J, DS8831N or DS8832N See NS Package J16A or N16A

## Truth Table (Shown for A Channels Only)

"A" OUTPU	T DISABLE	SINGLE	ENTIAL/ -ENDED ONTROL	INPUT A1	OUTPUT A1	INPUT A2	OUTPUT A2
0	0	,0	0	Logical "1" or Logical "0"	Same as Input A1	Logical "1" or Logical "0"	Same as Input A2
0	0	X 1	1 X	Logical "1" or Logical "0"	. Opposite of Input A1	Logical "1" or Logical "0"	Same as Input A2
1 X	X 1	×	<b>x</b> ,	×	High impedance state	. x	High impedance state

X = Don't Care

<b>Absolute Maximum R</b>	latings (Note 1)	Operating Cond	itions		
	_		MIN	MAX	UNITS
Supply Voltage	7V	Supply Voltage (VCC)			
Input Voltage	5.5V	DS7831, DS7832	4.5	5.5	V
Output Voltage	5.5V	DS8831, DS8832	4.75	5.25	V
Storage Temperature Range	-65°C to +150°C				
Time that 2 bus connected devices may		Temperature (T <sub>A</sub> )			
be in opposite low impedance states		DS7831, DS7832	-55	+125	°C
simultaneously	∞	DS8831, DS8832	0	+70	°C
Maximum Power Dissipation* at 25°C					
Cavity Package	1433 mW				
Molded Package	1362 mW				
Lead Temperature (Soldering, 10 sec.)	300°C				
*Derate cavity package 9.6 mW/°C abo package 10.9 mW/°C above 25°C.	ve 25°C; derate molded		·		

## Electrical Characteristics (Notes 2 and 3)

	PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS
V <sub>IH</sub>	Logical "1" Input Voltage	V <sub>CC</sub> ≈ Min			2.0			V
V <sub>IL</sub>	Logical "0" Input Voltage	V <sub>CC</sub> = Min					0.8	V
V <sub>OH</sub>	Logical "1" Output Voltage	DS7831, DS7	832	I <sub>O</sub> = -40 mA	1.8	2.3		V
		007001,007	V <sub>CC</sub> = Min	I <sub>O</sub> = -2 mA	2.4	2.7		V
		DS8831, DS8	1 00	I <sub>O</sub> = -40 mA	1.8	2.5		V
			552	I <sub>O</sub> = -5.2 mA	2.4	2.9		V
V <sub>OL</sub>	Logical "0" Output Voltage	DS7831, DS7	022	I <sub>O</sub> = 40 mA		0.29	0.50	V
	•	037031, 037	V <sub>CC</sub> = Min	I <sub>O</sub> = 32 mA			0.40	V
		DS8831, DS8		I <sub>O</sub> = 40 mA		0.29	0.50	V
		500001, 500	002	I <sub>O</sub> = 32 mA	<u> </u>		0.40	V
I <sub>IH</sub>	Logical "1" Input Current	V <sub>CC</sub> = Max	DS7831, DS7832,	V <sub>IN</sub> = 5.5V			1	mA
		VCC - IVIAX	DS8831, DS8832,	V <sub>IN</sub> = 2.4V			40	μΑ
I <sub>IL</sub>	Logical "0" Input Current	V <sub>CC</sub> = Max, \	/ <sub>IN</sub> = 0.4V			-1.0	-1.6	mA
I <sub>OD</sub>	Output Disable Current	V <sub>CC</sub> = Max, \	/ <sub>O</sub> = 2.4V or 0.4V		-40		40	μΑ
I <sub>sc</sub>	Output Short Circuit Current	V <sub>CC</sub> = Max, (	Note 4)		-40	-100	-120	mA
Icc	Supply Current	V <sub>CC</sub> = Max ir	TRI-STATE			65	90	mA
V <sub>CLI</sub>	Input Diode Clamp Voltage	V <sub>CC</sub> = 5.0V,	T <sub>A</sub> = 25°C, I <sub>IN</sub> = -	I2 mA			-1.5	V
V <sub>CLO</sub>	Output Diode Clamp Voltage	V <sub>CC</sub> = 5.0V, T <sub>A</sub> = 25°C	I <sub>OUT</sub> = -12 mA	DS7831/DS8831 DS7832/DS8832			-1.5	٧
		1 <sub>A</sub> - 25 C	I <sub>OUT</sub> = 12 mA	DS7831/DS8831			V <sub>CC</sub> +1.5	V

## Switching Characteristics $T_A = 25^{\circ}C$ , $V_{CC} = 5V$ , unless otherwise noted

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd0</sub>	Propagation Delay to a Logical "O" from Inputs A1, A2, B1, B2 Differential Single-ended Mode Control to Outputs			13	25	ns
t <sub>pd1</sub>	Propagation Delay to a Logical "1" from Inputs A1, A2, B1, B2 Differential Single-ended Mode Control to Outputs	·		13	25	ns
t <sub>1H</sub>	Delay from Disable Inputs to High Impedance State (from Logical "1" Level)	R <sub>L</sub> = 400Ω, C <sub>L</sub> = 15 pF See Figures 4 and 5		6 ,	. 12	ns
t <sub>OH</sub>	Delay from Disable Inputs to High Impedance State (from Logical "0" Level)			14	22	ns
t <sub>H1</sub>	Propagation Delay from Disable Inputs to Logical "1" Level (from High Impedance State)			14 .	22	ns
t <sub>H0</sub>	Propagation Delay from Disable Inputs to Logical "O" Level (from High Impedance State)			18	27	ns

#### **Notes**

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS7831 and DS7832 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8831 and DS8832. All typical values are for  $T_{A} = 25^{\circ}$ C and  $V_{CC} = 5V$ .

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

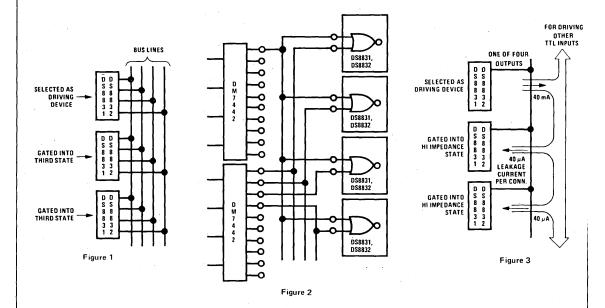
Note 4: Applies for TA = 125°C only. Only one output should be shorted at a time.

#### Mode of Operation (Continued)

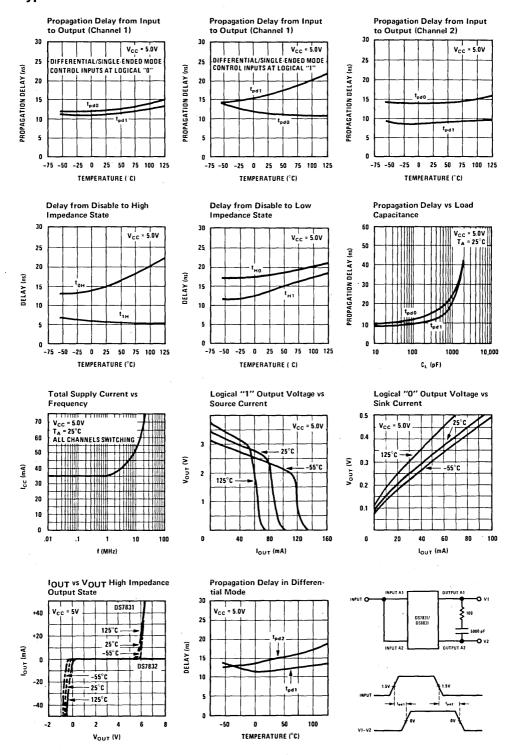
DS7831/DS8831's, DS7832/DS8832's (Figure 1), all devices except one must be placed in the "high impedance" state. This is accomplished by ensuring that a logical "1" is applied to at least one of the Output Disable pins of each device which is to be in the "high impedance" state. A NOR gate was purposely chosen for this function since it is possible with only two DM5442/DM7442, BCD-to-decimal decoders, to decode as many as 100 DS7831/DS8831's, DS7832/DS8832's (Figure 2).

The unique device whose Disable inputs receive two logical "0" levels assumes the normal low

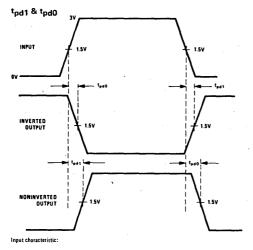
impedance output state, providing good capacitive drive capability and waveform integrity especially during the transition from the logical "0" to logical "1" state. The other outputs—in the high impedance state—take only a small amount of leakage current from the low impedance outputs. Since the logical "1" output current from the selected device is 100 times that of a conventional Series 54/74 device (40 mA vs. 400  $\mu$ A), the output is easily able to supply that leakage current for several hundred other DS7831/DS8831's, DS7832/DS8832's and still have available drive for the bus line (Figure 3).



#### **Typical Performance Characteristics**



## **Switching Time Waveforms**



 $\label{eq:amplitude} Amplitude = 3.0V \\ Frequency = 1.0 \ MHz, 50\% \ duty \ cycle \\ t_r = t_f \leq 10 \ ns \ (10\% \ to \ 90\%)$ 

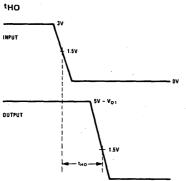


FIGURE 4

tOH

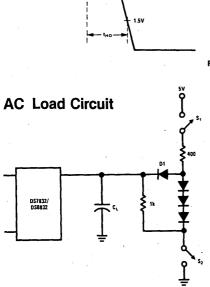
ACTUAL LOGICAL "D' VOLTAGE

<sup>t</sup>1H

ACTUAL LOGICAL VOLTAGE

tH1

OUTPUT



	Switch S1	Switch S2	CL
tpat	closed	closed	50 pF
1,00	closed	closed	50 pF
t <sub>oH</sub>	closed	closed	* 5 pF
t <sub>1H</sub>	closed	closed	* 5 pF
t <sub>HO</sub>	closed	open	50 pF
t <sub>H 1</sub>	open	closed	50 pF

<sup>\*</sup>Jig capacitance.



# DS78C120/DS88C120 Dual CMOS Compatible Differential Line Receiver

#### **General Description**

The DS78C120 and DS88C120 are high performance, dual differential, CMOS compatible line receivers for both balanced and unbalanced digital data transmission. The inputs are compatible with EIA, Federal and MIL standards.

Input specifications meet or exceed those of the popular DS7820/DS8820 line receiver.

#### **Features**

- Full compatibility with EIA Standards RS232-C, RS422 and RS423, Federal Standards 1020, 1030 and MIL-188-114
- Input voltage range of ±15V (differential or commonmode)
- Separate strobe input for each receiver
- 1/2 VCC strobe threshold for CMOS compatibility
- 5k typical input impedance

- 50 mV input hysteresis
- 200 mV input threshold
- Operation voltage range = 4.5V to 15V
- Separate fail-safe mode

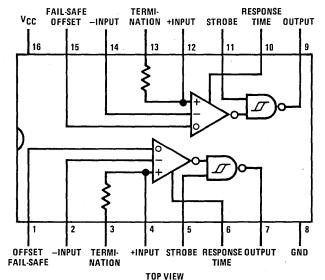
#### **Functional Description**

The line receiver will discriminate a  $\pm 200$  mV input signal over a common-mode range of  $\pm 10$ V and a  $\pm 300$  mV signal over a range of  $\pm 15$ V.

Circuit features include hysteresis and response control for applications where controlled rise and fall times and/ or high frequency noise rejection are desirable. Threshold offset control is provided for fail-safe detection, should the input be open or short. Each receiver includes a 180 $\Omega$  terminating resistor and the output gate contains a logic strobe for time discrimination. The DS78C120 is specified over a -55°C to +125°C temperature range and the DS88C120 from 0°C to +70°C.

#### **Connection Diagram**

#### **Dual-In-Line Package**



Order Number DS78C120J, DS88C120J or DS88C120N See NS Package J16A or N16A

Absolute Maximum Ratings (Note 1)		Operating Conditions						
Supply Voltage Input Voltage	18V ± <b>25V</b> 18V	Supply Voltage (V <sub>CC</sub> ) Temperature (T <sub>A</sub> )	MIN 4.5	MAX 15	UNITS V			
Strobe Voltage Output Sink Current Maximum Power Dissipation* at 25° C	50 mA	DS78C120 DS88C120	-55 0	+125 +70	°c °c			
Cavity Package Molded Package Storage Temperature Range	1433 mW 1362 mW -65° C to +150° C	Common-Mode Voltage (V <sub>CM</sub> )	<b>-15</b>	+15	٧			
Lead Temperature Nange Lead Temperature (Soldering, 10 seconds)  *Derate cavity package 9.6 mW/°C above 25° package 10.9 mW/°C above 25° C.	300°C							

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER CONDITIONS		MIN	TYP	MAX	UNITS	
VTH	Differential Threshold Voltage	I <sub>OUT</sub> = -200 μA,	$-7V \le V_{CM} \le 7V$ -15V < $V_{CM} \le 15V$		0.06 0.06	0.2	V
		V <sub>OUT</sub> ≥ V <sub>CC</sub> – 1.2V	-7V ≤ V <sub>CM</sub> ≤ 7V		-0.08	-0.2	l v
VTL	Differential Threshold Voltage	$I_{OUT}$ = 1.6 mA, $V_{OUT} \le 0.5V$	-15V ≤ V <sub>CM</sub> ≤ 15V		-0.08	-0.3	V
V <sub>TH</sub>	Differential Threshold Voltage	I <sub>OUT</sub> = -200 μA, V <sub>OUT</sub> ≥ V <sub>CC</sub> - 1.2V	-7V ≤ V <sub>CM</sub> ≤ 7V	-	0.47	0.7	V
VTL	Fail-Safe Offset = 5V	I <sub>OUT</sub> = 1.6 mA, V <sub>OUT</sub> ≤ 0.5V	$-7V \le V_{CM} \le 7V$	0.2	0.42		V
RIN	Input Resistance	$-15V \le V_{CM} \le 15V, \ 0V \le V_{CC} \le 15V$	15V	4	5		kΩ
RΤ	Line Termination Resistance	T <sub>A</sub> = 25°C		100	180	300	Ω
RO	Offset Control Resistance	T <sub>A</sub> = 25°C			56 ·		kΩ
IND Data Input Current (Unterminated)			V <sub>CM</sub> = 10V		2	3.1	mA
		0V ≤ V <sub>CC</sub> ≤ 15V	VCM = 0V		0	-0.5	mA
			V <sub>CM</sub> = -10V		-2	−3.1	mA
Vтнв	Input Balance	$I_{OUT} = 200 \mu\text{A},  V_{OUT} \ge V_{CC} - 1.2 \text{V},  R_S = 500 \Omega,  (\text{Note 5})$	-7V ≤ V <sub>CM</sub> ≤ 7V		0.1	0.4	V
		$I_{OUT}$ = 1.6 mA, $V_{OUT} \le 0.5V$ , RS = 500Ω, (Note 5)	-7V ≤ V <sub>CM</sub> ≤ 7V		-0.1	-0.4	V
۷он	Logical "1" Output Voltage	I <sub>OUT</sub> = -200 μA, V <sub>DIFF</sub> = 1V		V <sub>CC</sub> -1.2	V <sub>CC</sub> -0.75		V
VOL	Logical "0" Output Voltage	IOUT = 1.6 mA, VDIFF = -1V			0.25	0.5	l V
Icc	Power Supply Current	$15V \leq V_{CM} \leq -15V$ ,	V <sub>CC</sub> = 5.5V		8	15	mA
		VDIFF = -0.5V (Both Receivers)	V <sub>CC</sub> = 15V		15	30	mA
<sup>1</sup> IN(1)	Logical "1" Strobe Input Current	VSTROBE = 15V, VDIFF = 3V			15	100	μΑ
(0)NI	Logical "0" Strobe Input Current	VSTROBE = 0V, VDIFF = -3V			-0.5	-100	μΑ
٧ <sub>IH</sub>	Logical "1" Strobe Input Voltage		V <sub>CC</sub> = 5V	3.5	2.5		V
	•	V <sub>OL</sub> ≤ 0.5V, I <sub>OUT</sub> = 1.6 mA	V <sub>CC</sub> = 10V	8.0	5.0		V
		<u> </u>	V <sub>CC</sub> = 15V	12.5	7.5		٧
VIL	Logical "0" Strobe Input Voltage	V <sub>OH</sub> = V <sub>CC</sub> - 1.2V,	V <sub>CC</sub> = 5V		2.5	1.5	V
		VOH - VCC - 1.2V, IOUT = -200 μA	V <sub>CC</sub> = 10V		5.0	2.0	V
		1001200 μΑ	V <sub>CC</sub> = 15V		7.5	2.5	V
los	Output Short-Circuit Current	VOUT = 0V, VCC = 15V, VSTROE	E = 0V, (Note 4)	-5	-20	-40	mA

## Switching Characteristics $V_{CC} = 5V$ , $T_A = 25^{\circ}C$

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
tpd0(D) Differential Input to "0" Output	C <sub>L</sub> = 50 pF		60	100	ns
tpd1(D) Differential Input to "1" Output	C <sub>L</sub> = 50 pF		100	150	ns
tpd0(S) Strobe Input to "0" Output	C <sub>L</sub> = 50 pF		30	70	ns
tpd1(S) Strobe Input to "1" Output	C <sub>L</sub> = 50 pF		100	150	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS78C120 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS88C120. All typical values are for  $T_A = 25^{\circ}$ C,  $V_{CC} = 5V$  and  $V_{CM} = 0V$ .

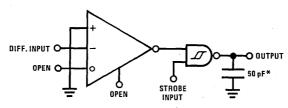
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

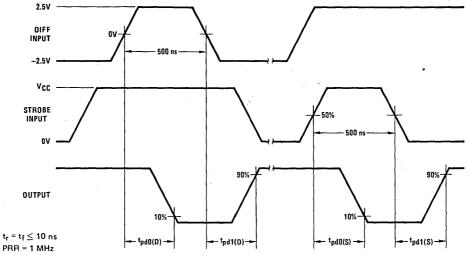
Note 5: Refer to EIA-RS422 for exact conditions.

## **AC Test Circuit and Switching Time Waveforms**

Differential and Strobe Input Signal



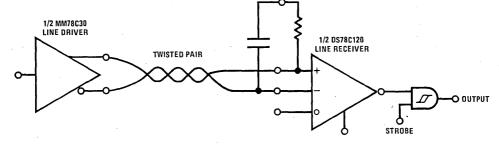
\*Includes probe and test fixture capacitance



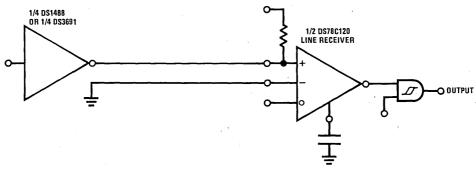
Note. Optimum switching response is obtained by minimizing stray capacitance on Response Control pin (no external connection).

## **Application Hints**

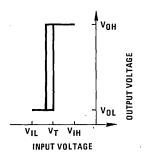
#### **Balanced Data Transmission**

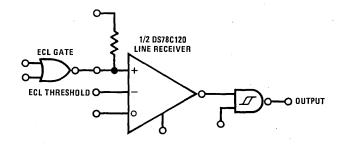


#### Unbalanced Data Transmission



#### Logic Level Translator





The DS78C120/DS88C120 may be used as a level translator to interface between ±12V MOS, ECL, TTL and CMOS. To configure, bias either input to a voltage equal to 1/2 the voltage of the input signal, and the other input to the driving gate.

#### **LINE DRIVERS**

Line drivers which will interface with the DS78C120/ DS88C120 are listed below.

#### **Balanced Drivers**

Quad RS422 Line Driver
Dual CMOS
Dual TTL
Dual TRI-STATE® TTL
Dual TRI-STATE TTL
Quad RS423/Dual RS422 TTL
Quad RS423/Dual TRI-STATE
RS422 TTL

Quad TRI-STATE RS422

## DS3587, DS3487 **Unbalanced Drivers**

DS1488	Quad RS232
DS75150	Dual RS232

#### RESPONSE CONTROL AND HYSTERESIS

In unbalanced (RS232/RS423) applications it is recommended that the rise time and fall time of the line driver be controlled to reduce cross-talk. Elimination of switching noise is accomplished in the DS78C120/ DS88C120 by the 50 mV of hysteresis incorporated in the output gate. This eliminates the oscillations which may appear in a line receiver due to the input signal slowly varying about the threshold level for extended periods of time.

High frequency noise which is superimposed on the input signal which may exceed 50 mV can be reduced in amplitude by filtering the device input. On the DS78C120/DS88C120, a high impedance response control pin in the input amplifier is available to filter the input signal without affecting the termination impedance of the transmission line. Noise pulse width rejection vs the value of the response control capacitor is shown in Figures 1 and 2. This combination of filters followed by hysteresis will optimize performance in a worse case noise environment.

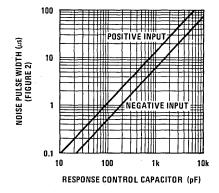
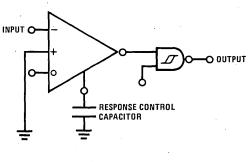
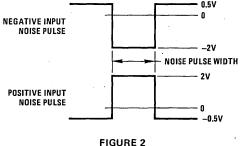


FIGURE 1. Noise Pulse Width vs Response **Control Capacitor** 





#### TRANSMISSION LINE TERMINATION

On a transmission line which is electrically long, it is advisable to terminate the line in its characteristic impedance to prevent signal reflection and its associated noise/cross-talk. A 180 $\Omega$  termination resistor is provided in the DS78C120/DS88C120 line receiver. To use the termination resistor, connect pins 2 and 3 together and pins 13 and 14 together. The  $180\Omega$  resistor provides a good compromise between line reflections, power dissipation in the driver, and IR drop in the transmission line. If power dissipation and IR drop are still a concern, a capacitor may be connected in series with the resistor to minimize power loss.

The value of the capacitor is recommended to be the line length (time) divided by 3 times the resistor value. Example: if the transmission line is 1,000 feet long, (approximately 1000 ns) the capacitor value should be 1852 pF. For additional application details, refer to application notes AN-22 and AN-108 in the National Semiconductor Interface Data Book.

#### **FAIL-SAFE OPERATION**

Communication systems require elements of a system to detect the presence of signals in the transmission lines, and it is desirable to have the system shut-down in a fail-safe mode if the transmission line is open or short. To facilitate the detection of input opens or shorts, the DS78C120/DS8C120 incorporates an input threshold voltage offset. This feature will force the line receiver to a specific logic state if presence of either fault is a condition.

Given that the receiver input threshold is  $\pm 200$  mV, an input signal greater than  $\pm 200$  mV insures the receiver will be in a specific logic state. When the offset control input (pins 1 and 15) is connected to  $V_{CC}=5V$ , the

input thresholds are offset from 200 mV to 700 mV, referred to the non-inverting input, or -200 mV to -700 mV, referred to the inverting input. Therefore, if the input is open or short, the input will be greater than the input threshold and the receiver will remain in a specified logic state.

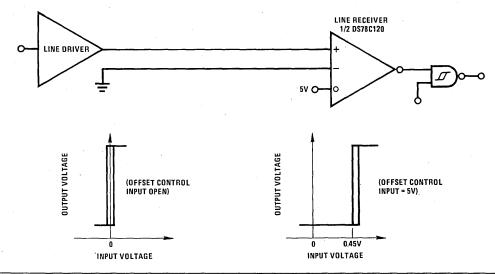
The input circuit of the receiver consists of a 5k resistor terminated to ground through  $120\Omega$  on both inputs. This network acts as an attenuator, and permits operation with common-mode input voltages greater than ±15V. The offset control input is actually another input to the attenuator, but its resistor value is 56k. The offset control input is connected to the inverting input side of the attenuator, and the input voltage to the amplifier is the sum of the inverting input plus 0.09 times the voltage on the offset control input. When the offset control input is connected to 5V the input amplifier will see VIN(INVERTING) + 0.45V or VIN(IN-VERTING) + 0.9V when the control input is connected to 10V. The offset control input will not significantly affect the differential performance of the receiver over its common-mode operating range, and will not change the input impedance balance of the receiver.

It is recommended that the receiver be terminated (500  $\!\Omega$  or less) to insure it will detect an open circuit in the presence of noise.

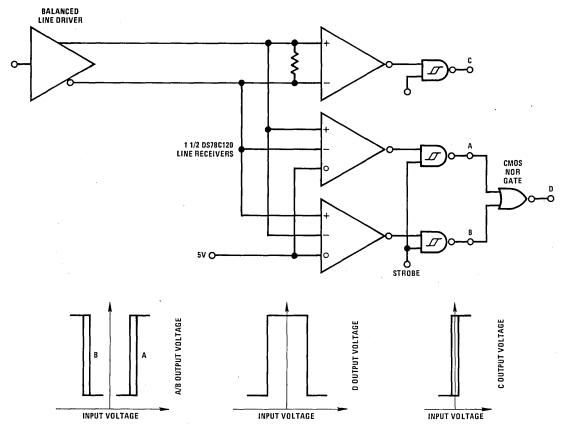
The offset control can be used to insure fail-safe operation for unbalanced interface (RS423) or for balanced interface (RS422) operation.

For unbalanced operation, the receiver would be in an indeterminate logic state if the offset control input was open. Connecting the offset to 5V offsets the receiver threshold 0.45V. The output is forced to a logic zero state if the input is open or short.

#### Unbalanced RS423 and RS232 Fail-Safe



Balanced RS422 Fail-Safe



For balanced operation with inputs short or open, receiver C will be in an indeterminate logic state. Receivers A and B will be in a logic zero state allowing the NOR gate to detect the short or open condition. The strobe will disable receivers A and B and may therefore be used to sample the fail-safe detector. Another method of fail-safe detection consists of filtering the output of the NOR gate D so it would not indicate a fault condition when receiver inputs pass through the threshold region, generating an output transient.

In a communications system, only the control signals are required to detect input fault conditions. Advantages of a balanced data transmission system over an unbalanced transmission system are:

- 1. High noise immunity
- 2. High data ratio
- 3 Long line lengths

Truth Table (For Balanced Fail-Safe)

INPUT	STROBE	A-OUT	B-OUT	C-OUT	D-OUT
0	1	0	1	0	0
1 . '	1 1	1	0	1	0
X	1	0	0	X	1
0	0	1	· 1	0	0
1	0	1	1	0	0
Х	0	1	1	0	0



# DS78LS120/DS88LS120 Dual Differential Line Receiver (Noise Filtering and Fail-Safe)

#### **General Description**

The DS78LS120 and DS88LS120 are high performance, dual differential TTL compatible line receivers for both balanced and unbalanced digital data transmission. The inputs are compatible with EIA, Federal and MIL standards.

The line receiver will discriminate a  $\pm 200$  mV input signal over a common-mode range of  $\pm 10$ V and a  $\pm 300$  mV signal over a range of  $\pm 15$ V.

Circuit features include hysteresis and response control for applications where controlled rise and fall times and/ or high frequency noise rejection are desirable. Threshold offset control is provided for fail-safe detection, should the input be open or short. Each receiver includes an optional  $180\Omega$  terminating resistor and the output gate contains a logic strobe for time discrimination. The DS78LS120 is specified over a  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  temperature range and the DS88LS120 from 0°C to  $+70^{\circ}\text{C}$ .

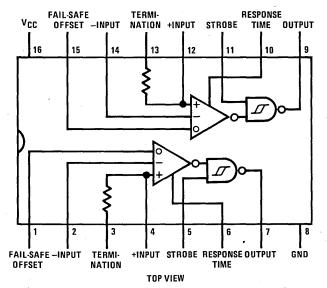
Input specifications meet or exceed those of the popular DS7820/DS8820 line receiver.

#### **Features**

- Meets EIA Standards RS232-C, RS422 and RS423, Federal Standards 1020, 1030 and MIL-188-114
- Input voltage range of ±15V (differential or commonmode)
- Separate strobe input for each receiver
- 5k typical input impedance
- Optional 180Ω termination resistor
- 50 mV input hysteresis
- 200 mV input threshold
- Separate fail-safe mode

## **Connection Diagram**

#### Dual-In-Line Package



Order Number DS78LS120J, DS88LS120J or DS88LS120N See NS Package J16A or N16A

#### **Absolute Maximum Ratings** (Note 1) **Operating Conditions** MIN MAX UNITS Supply Voltage (V<sub>CC</sub>) 4.5 5.5 ٧ Supply Voltage Input Voltage ±25V Temperature (TA) Strobe Voltage °C 7V DS78LS120 -55 +125 50 mA °C **Output Sink Current** DS88LS120 0 +70 -65°C to +150°C Storage Temperature Range Common-Mode Voltage (V<sub>CM</sub>) -15 +15 Maximum Power Dissipation\* at 25°C Cavity Package 1433 mW Molded Package 1362 mW Lead Temperature (Soldering, 10 seconds) 300°C \*Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.9 mW/° C above 25° C.

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
.,	B	100 \	$-7V \le V_{CM} \le 7V$		0.06	0.2	V
VTH	Differential Threshold Voltage	$1_{OUT} = -400 \mu\text{A},  V_{OUT} \ge 2.5V$ $-15V \le V_{CM} \le 15V$			0.06	0.3	٧
VTL	Differential Threshold Voltage	IOUT = 4 mA, VOUT < 0.5V	$-7V \le V_{CM} \le 7V$		-0.08	-0.2	V
*16		1001 1 1111, 1001 2 5.51	$-15V \le V_{CM} \le 15V$		-0.08	-0.3	V
$v_{TH}$	Differential Threshold Voltage	$I_{OUT} = -400 \mu\text{A}, V_{OUT} \ge 2.5 \text{V}$	$-7V \le V_{CM} \le 7V$		0.47	0.7	V
VTL	With Fail Safe Offset = 5V	$I_{OUT} = 4 \text{ mA, } V_{OUT} \le 0.5$	$-7V \le V_{CM} \le 7V$	-0.2	-0.42		V
RIN	Input Resistance	$-15V \le V_{CM} \le 15V$ , $0V \le V_{CC} \le$	7V	4	5		kΩ
RŢ	Line Termination Resistance	T <sub>A</sub> = 25°C		100	180	300	Ω
RO	Offset Control Resistance	T <sub>A</sub> = 25°C		42	56	70	kΩ
IIND	Data Input Current (Unterminated)	V <sub>CM</sub> = 10V			2	3,1	mA
		V <sub>CM</sub> = 0V	$0V \le V_{CC} \le 7V$	ļ	0	-0.5	mA
	·	V <sub>CM</sub> = -10V	ĺ	1	-2	-3.1	,mA
Vтнв	Input Balance	$I_{OUT} = -400 \mu A$ , $V_{OUT} \ge 2.5 V$ , R <sub>S</sub> = 500Ω, (Note 5)	-7V ≤ V <sub>CM</sub> ≤ 7V		0.1	0.4	٧
		$I_{OUT}$ = 4 mA, $V_{OUT} \le 0.5V$ , R <sub>S</sub> = 500 $\Omega$ , (Note 5)	-7V ≤ V <sub>CM</sub> ≤ 7V		-0.1	-0.4	V
Voн	Logical "1" Output Voltage	$I_{OUT} = -400 \mu\text{A}, V_{DIFF} = 1V, V_{C}$	C = 4.5V	2.5	3		V
VOL	Logical "0" Output Voltage	IOUT = 4 mA, VDIFF = -1V, VCC	= 4.5V		0.35	0.5	V
Icc	Power Supply Current	V <sub>CC</sub> = 5.5V,	V <sub>CM</sub> = 15V		9	. 12	mA
		V <sub>DIFF</sub> = -0.5V, (Both Receivers)	V <sub>CM</sub> = -15V	,	10	16	. mA
IN(1)	Logical "1" Strobe Input Current	VSTROBE = 5.5V, VDIFF = 3V			1	100	μА
IN(0)	Logical "0" Strobe Input Current	V <sub>STROBE</sub> = 0V, V <sub>DIFF</sub> = -3V			-290	-400	μΑ
VIH	Logical "1" Strobe Input Voltage	V <sub>OL</sub> ≤ 0.5, I <sub>OUT</sub> = 4 mA		2.0	1.12		V
ΫIL	Logical "0" Strobe Input Voltage	V <sub>OH</sub> ≥ 2.5V, I <sub>OUT</sub> = −400 μA			1.12	0.8	٧
los	Output Short-Circuit Current	V <sub>OUT</sub> = 0V, V <sub>CC</sub> = 5.5V, V <sub>STROBE</sub> = 0V, (Note 4)			-100	-170	mA

## Switching Characteristics V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C

PARAMETER CONDITIONS		MIN	TYP	MAX	UNITS
tpd0(D) Differential Input to "0" Output	Response Pin Open, CL = 15 pF, RL = $2  k\Omega$		38	60	ns
tpd1(D) Differential Input to "1" Output			38	60	ns '
tpd0(S) Strobe Input to "0" Output			16	25	ns
tpd1(S) Strobe Input to "1" Output			12	25	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

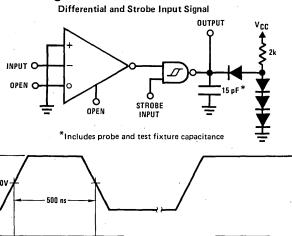
Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS78LS120 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C for the DS88LS120. All typical values are for T<sub>A</sub> =  $25^{\circ}$ C, V<sub>CC</sub> = 5V and V<sub>CM</sub> = 0V.

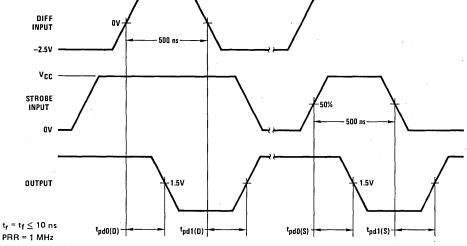
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: Refer to EIA-RS422 for exact conditions.

## **AC Test Circuit and Switching Time Waveforms**



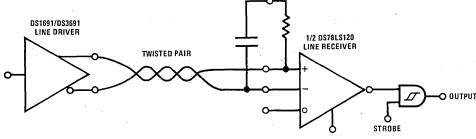


Note. Optimum switching response is obtained by minimizing stray capacitance on Response Control pin (no external connection).

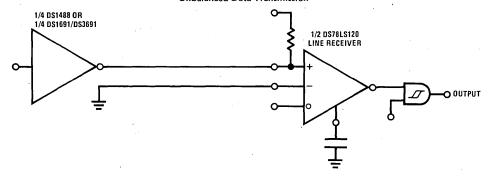
## **Application Hints**

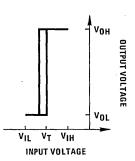
2.5V

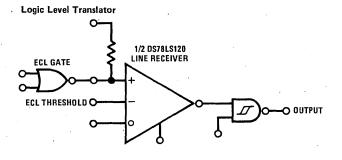
#### **Balanced Data Transmission**



#### **Unbalanced Data Transmission**







The DS78LS120/DS88LS120 may be used as a level translator to interface between ±12V MOS, ECL, TTL and CMOS. To configure, bias either input to a voltage equal to 1/2 the voltage of the input signal, and the other input to the driving gate.

#### LINE DRIVERS

Line drivers which will interface with the DS78LS120/ DS88LS120 are listed below.

#### **Balanced Drivers**

DS26LS31 Quad RS422 Line Driver MM87C30, MM88C30 **Dual CMOS** DS7830, DS8830 **Dual TTL** DS7831, DS8831 Dual TRI-STATE® TTL DS7832, DS8832 Dual TRI-STATE TTL DS1691, DS3691 Quad RS423/Dual RS422 TTL DS1692, DS3692 Quad RS423/Dual TRI-STATE RS422 TTL

DS1488 Quad RS232 DS75150 Dual RS232

#### **Unbalanced Drivers**

DS3487

Quad TRI-STATE RS422

#### RESPONSE CONTROL AND HYSTERESIS

In unbalanced (RS232/RS423) applications it is recommended that the rise time and fall time of the line driver be controlled to reduce cross-talk. Elimination of switching noise is accomplished in the DS78LS120/ DS88LS120 by the 50 mV of hysteresis incorporated in the output gate. This eliminates the oscillations which may appear in a line receiver due to the input signal slowly varying about the threshold level for extended periods of time.

High frequency noise which is superimposed on the input signal which may exceed 50 mV can be reduced in amplitude by filtering the device input. On the DS78LS120/DS88LS120, a high impedance response control pin in the input amplifier is available to filter the input signal without affecting the termination impedance of the transmission line. Noise pulse width rejection vs the value of the response control capacitor is shown in Figures 1 and 2. This combination of filters followed by hysteresis will optimize performance in a worse case noise environment.

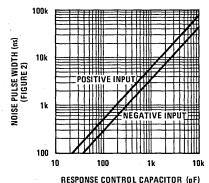
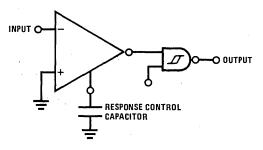


FIGURE 1. Noise Pulse Width vs **Response Control Capacitor** 



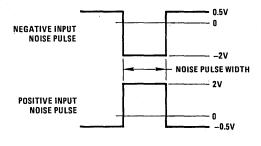


FIGURE 2

### Application Hints (Continued)

#### TRANSMISSION LINE TERMINATION

On a transmission line which is electrically long, it is advisable to terminate the line in its characteristic impedance to prevent signal reflection and its associated noise/cross-talk. A 180 $\Omega$  termination resistor is provided in the DS78LS120/DS88LS120 line receiver. To use the termination resistor, connect pins 2 and 3 together and pins 13 and 14 together. The  $180\Omega$  resistor provides a good compromise between line reflections, power dissipation in the driver, and IR drop in the transmission line. If power dissipation and IR drop are still a concern. a capacitor may be connected in series with the resistor to minimize power loss.

The value of the capacitor is recommended to be the line length (time) divided by 3 times the resistor value. Example: if the transmission line is 1,000 feet long, (approximately 1000 ns), and the termination resistor value is 180  $\!\Omega$  , the capacitor value should be 1852 pF. For additional application details, refer to application notes AN-22 and AN-108 in the National Semiconductor Interface Data Book.

#### **FAIL-SAFE OPERATION**

Communication systems require elements of a system to detect the presence of signals in the transmission lines, and it is desirable to have the system shut-down in a fail-safe mode if the transmission line is open or short. To facilitate the detection of input opens or shorts, the DS78LS120/DS88LS120 incorporates an input threshold voltage offset. This feature will force the line receiver to a specific logic state if presence of either fault is a condition.

Given that the receiver input threshold is ±200 mV. an input signal greater than ±200 mV insures the receiver will be in a specific logic state. When the offset control input (pins 1 and 15) is connected to  $V_{CC} = 5V$ , the

input thresholds are offset from 200 mV to 700 mV, referred to the non-inverting input, or -200 mV to -700 mV, referred to the inverting input. Therefore, if the input is open or short, the input will be greater than the input threshold and the receiver will remain in a specified logic state.

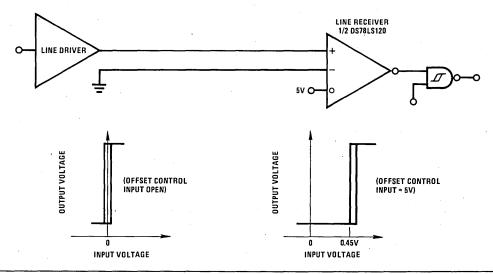
The input circuit of the receiver consists of a 5k resistor terminated to ground through  $120\Omega$  on both inputs. This network acts as an attenuator, and permits operation with common-mode input voltages greater than ±15V. The offset control input is actually another input to the attenuator, but its resistor value is 56k. The offset control input is connected to the inverting input side of the attenuator, and the input voltage to the amplifier is the sum of the inverting input plus 0.09 times the voltage on the offset control input. When the offset control input is connected to 5V the input amplifier will see VIN(INVERTING) + 0.45V or VIN(IN-VERTING) + 0.9V when the control input is connected to 10V. The offset control input will not significantly affect the differential performance of the receiver over its common-mode operating range, and will not change the input impedance balance of the receiver.

It is recommended that the receiver be terminated  $(500\Omega \text{ or less})$  to insure it will detect an open circuit in the presence of noise.

The offset control can be used to insure fail-safe operation for unbalanced interface (RS423) or for balanced interface (RS422) operation.

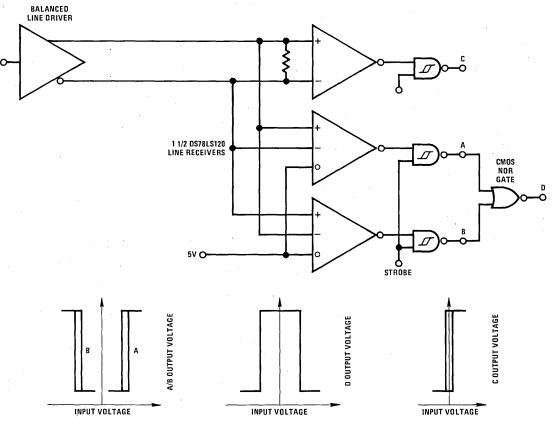
For unbalanced operation, the receiver would be in an indeterminate logic state if the offset control input was open. Connecting the offset to 5V offsets the receiver threshold 0.45V. The output is forced to a logic zero state if the input is open or short.

#### Unbalanced RS423 and RS232 Fail-Safe



## Application Hints (Continued)

#### Balanced RS422 Fail-Safe



For balanced operation with inputs short or open, receiver C will be in an indeterminate logic state. Receivers A and B will be in a logic zero state allowing the NOR gate to detect the short or open condition. The strobe will disable receivers A and B and may therefore be used to sample the fail-safe detector. Another method of fail-safe detection consists of filtering the output of the NOR gate D so it would not indicate a fault condition when receiver inputs pass through the threshold region, generating an output transient.

In a communications system, only the control signals are required to detect input fault conditions. Advantages of a balanced data transmission system over an unbalanced transmission system are:

- 1. High noise immunity
- 2. High data ratio
- 3 Long line lengths

# Truth Table (For Balanced Fail-Safe)

INPUT	STROBE	A-OUT	B-OUT	C-OUT	D-OUT
0	1	0	1	0	0
1	1	1	0	1	0
) x	1	0	0	х	1.
0	0	1	1	0	0
1	0	1	1	0	0
X	0	1	1	0	0

# Integrated Circuits for Digital Data Transmission



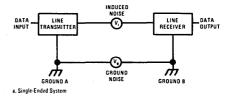
#### INTRODUCTION

It is frequently necessary to transmit digital data in a high-noise environment where ordinary integrated logic circuits cannot be used because they do not have sufficient noise immunity. One solution to this problem, of course, is to use high-noise-immunity logic. In many cases, this approach would require worst case logic swings of 30V, requiring high power-supply voltages. Further, considerable power would be needed to transmit these voltage levels at high speed. This is especially true if the lines must be terminated to eliminate reflections, since practical transmission lines have a low characteristic impedance.

A much better solution is to convert the ground referred digital data at the transmission end into a differential signal and transmit this down a balanced, twisted-pair line. At the receiving end, any induced noise, or voltage due to ground-loop currents, appears equally on both ends of the twisted-pair line. Hence, a receiver which responds only to the differential signal from the line will reject the undesired signals even with moderate voltage swings from the transmitter.

Figure 1 illustrates this situation more clearly. When ground is used as a signal return as in Figure 1a, the voltage seen at the receiving end will be the output voltage of the transmitter plus any noise voltage induced in the signal line. Hence, the noise immunity of the transmitter-receiver combination must be equal to the maximum expected noise from both sources.

The differential transmission scheme diagrammed in Figure 1b solves this problem. Any ground noise or voltage induced on the transmission lines will appear equally on both inputs of the receiver. The receiver responds only to the differential signal coming out of the twisted-pair line and delivers a single-ended output signal referred to the ground



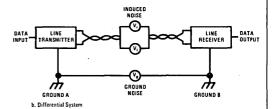


FIGURE 1. Comparing Differential and Single-Ended Data Transmission

at the receiving end. Therefore, extremely high noise immunities are not needed; and the transmitter and receiver can be operated from the same supplies as standard integrated logic circuits.

This article describes the operation and use of a line driver and line receiver for transmission systems using twisted-pair lines. The transmitter provides a buffered differential output from a DTL or TTL input signal. A four-input gate is included on the input so that the circuit can also perform logic. The receiver detects a zero crossing in the differential input voltage and can directly drive DTL or TTL integrated circuits at the receiving end. It also has strobe capability to blank out unwanted input signals. Both the transmitter and the receiver incorporate two independent units on a single silicon chip.

#### LINE DRIVER

Figure 2 shows a schematic diagram of the line transmitter. The circuit has a marked resemblance to a standard TTL buffer. In fact, it is possible to use a standard dual buffer as a transmitter. However, the DS7830 incorporates additional features. For one, the output is current limited to protect the driver from accidental shorts in the transmission lines. Secondly, diodes on the output clamp severe voltage transients that may be induced into the transmission lines. Finally, the circuit has internal inversion to produce a differential output signal, reducing the skew between the outputs and making the output state independent of loading.

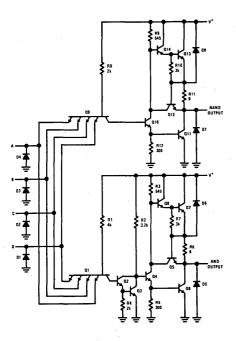


FIGURE 2. Schematic Diagram of the DS7830 Line Driver

As can be seen from the upper half of Figure 2, a quadruple-emitter input transistor,  $\Omega 9,\ provides$  four logic inputs to the transmitter. This transistor drives the inverter stage formed by Q10 and Q11

to give a NAND output. A low state logic input on any of the emitters of Q9 will cause the base drive to be removed from Q10, since Q9 will be saturated by current from R8, holding the base of Q10 near ground. Hence, Q10 and Q11 will be turned off; and the output will be in a high state. When all the emitters of Q9 are at a one logic level, Q10 receives base drive from R8 through the forward biased collector-base junction of Q9. This saturates Q10 and also Q11, giving a low output state. The input voltage at which the transition occurs is equal to the sum of the emitter-base turn on voltages of Q10 and Q11 minus the saturation voltage of Q9. This is about 1.4V at 25°C.

A standard "totem-pole" arrangement is used on the output stage. When the output is switched to the high state, with Q10 and Q11 cut off, current is supplied to the load by Q13 and Q14 which are connected in a modified Darlington configuration. Because of the high compound current gain of these transistors, the output resistance is quite low and a large load current can be supplied. R10 is included across the emitter-base junction of Q13 both to drain off any collector-base leakage current in Q13 and to discharge the collector-base capacitance of Q13 when the output is switched to the low state. In the high state, the output level is approximately two diode drops below the positive supply, or roughly 3.6V at 25°C with a 5.0V supply.

With the output switched into the low state, Q10 saturates, holding the base of Q14 about one diode drop above ground. This cuts off Q13. Further, both the base current and the collector current of Q10 are driven into the base of Q11 saturating it and giving a low-state output of about 0.1V. The circuit is designed so that the base of Q11 is supplied 6 mA, so the collector can drive considerable load current before it is pulled out of saturation.

The primary purpose of R12 is to provide current to remove the stored charge in Q11 and charge its collector base capacitance when the circuit is switched to the high state. Its value is also made enough less than R9 to prevent supply current transients which might otherwise occur\* when the power supply is coming up to voltage.

\*J. Kalb, "Design Considerations for a TTL Gate, "National Semiconductor TP-6, May, 1968.

The lower half of the transmitter in Figure 2 is identical to the upper, except that an inverter stage has been added. This is needed so that an input signal which drives the output of the upper half positive will drive the lower half negative, and vice versa, producing a differential output signal. Transistors O2 and O3 produce the inversion. Even though the current gain is not necessarily needed, the modified Darlington connection is used to produce the proper logic transition voltage on the input of the transmitter. Because of the low load capacitance that the inverter sees when it is completely within the integrated circuit, it is extremely fast, with a typical delay of 3 ns. This minimizes the skew between the outputs.

One of the schemes used when dual buffers are employed as a differential line driver is to obtain the NAND output in the normal fashion and provide the AND output by connecting the input of the second buffer to the NAND output. Using an internal inverter has some distinct advantages over this: for one, capacitive loads which slow down the response of the NAND output will not introduce a time skew between the two outputs; secondly, line transients on the NAND output will not cause an unwanted change of state on the AND output.

Clamp diodes, D1 through D4, are added on all inputs to clamp undershoot. This undershoot and ringing can occur in TTL systems because the rise and fall times are extremely short.

Output-current limiting is provided by adding a resistor and transistor to each of the complementary outputs. Referring again to Figure 2, when the current on the NAND output increases to a value where the voltage drop across R11 is sufficient to turn on Q12, the short circuit protection comes into effect. This happens because further increases in output current flow into the base of Q12 causing it to remove base drive from Q14 and, therefore, Q13. Any substantial increase in output current will then cause the output voltage to collapse to zero. Since the magnitude of the short circuit depends on the emitter base turn-on voltage of Q12, this current has a negative temperature coefficient. As the chip temperature increases from power dissipation, the available short circuit current is reduced. The current limiting also serves to control the current transient that occurs when

the output is going through a transition with both Q11 and Q13 turned on.

The AND output is similarly protected by R6 and Q5, which limit the maximum output current to about 100 mA, preventing damage to the circuit from shorts between the outputs and ground.

The current limiting transistors also serve to increase the low state output current capability under severe transient conditions. For example, when the current into the NAND output becomes so high as to pull Q11 out of saturation, the output voltage will rise to two diode drops above ground. At this voltage, the collector-base junction of Q12 becomes forward biased and supplies additional base drive to Q11 through Q10 which is saturated. This minimizes any further increase in output voltage.

When either of the outputs are in the high state, they can drive a large current towards ground without a significant change in output voltage. However, noise induced on the transmission line which tries to drive the output positive will cut it off since it cannot sink current in this state. For this reason, D6 and D8 are included to clamp the output and keep it from being driven much above the supply voltage, as this could damage the circuit.

When the output is in a low state, it can sink a lot of current to clamp positive-going induced voltages on the transmission line. However, it cannot source enough current to eliminate negative-going transients so D5 and D7 are included to clamp those voltages to ground.

It is interesting to note that the voltage swing produced on one of the outputs when the clamp diodes go into conduction actually increases the differential noise immunity. For example with no induced common mode current, the low-state output will be a saturation voltage above ground while the high output will be two diode drops below the positive supply voltage. With positive-going common mode noise on the line, the low output remains in saturation; and the high output is clamped at a diode drop above the positive supply. Hence, in this case, the common mode noise increases the differential swing by three diode drops.

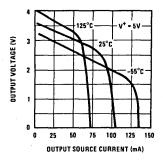


FIGURE 3. High State Output Voltage as a Function of Output Current

Having explained the operation of the line driver, it is appropriate to look at the performance in more detail. Figure 3 shows the high-state output characteristics under load. Over the normal range of output currents, the output resistance is about  $10\Omega$ . With higher output currents, the short circuit protection is activated, causing the output voltage to drop to zero. As can be seen from the figure, the short-circuit current decreases at higher temperatures to minimize the possibility of overheating the integrated circuit.

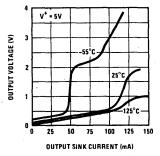


FIGURE 4. Low-State Output Current as a Function of Output Current

Figure 4 is a similar graph of the low-state output characteristics. Here, the output resistance is about  $5\Omega$  with normal values of output current. With larger currents, the output transistor is pulled out of saturation; and the output voltage increases. This is most pronounced at  $-55^{\circ}\mathrm{C}$  where the transistor current gain is the lowest. However, when the output voltage rises about two diode drops above ground, the collector-base junction of the current-limit transistor becomes forward biased,

providing additional base drive for the output transistor. This roughly doubles the current available for clamping positive common-mode transients on the twisted-pair line. It is interesting to note that even though the output level increases to about 2V under this condition, the differential noise immunity does not suffer because the high-state output also increases by about 3V with positive going common-mode transients.

It is clear from the figure that the low state output current is not effectively limited. Therefore, the device can be damaged by shorts between the output and the 5V supply. However, protection against shorts between outputs or from the outputs to ground is provided by limiting the highstate current.

The curves in Figures 3 and 4 demonstrate the performance of the line driver with large, capacitively-coupled common-mode transients, or under

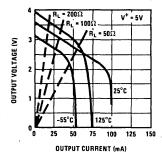


FIGURE 5. Differential Output Voltage as a Function of Differential Output Current

gross overload conditions. Figure 5 shows the ability of the circuit to drive a differential load: that is, the transmission line. It can be seen that for output currents less than 35 mA, the output resistance is approximately  $15\Omega.$  At both temperature extremes, the output falls off at high currents. At high temperatures, this is caused by current limiting of the high output state. At low temperatures, the falloff of current gain in the low-state output transistor produces this result.

Load lines have been included on the figure to show the differential output with various load resistances. The output swing can be read off from the intersection of the output characteristic with the load line. The figure shows that the driver can easily handle load resistances greater than  $100\Omega$ .

This is more than adequate for practical, twisted-pair lines.

Figure 6 shows the no load power dissipation, for one-half of the dual line driver, as a function of frequency. This information is important for two reasons. First, the increase in power dissipation at high frequencies must be added to the excess power dissipation caused by the load to determine the total package dissipation. Second, and more important, it is a measure of the "glitch" current which flows from the positive supply to ground through the output transistors when the circuit is going through a transition. If the output stage is

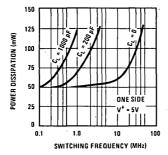


FIGURE 6. Power Dissipation as a Function of Switching Frequency

not properly designed, the current spikes in the power supplies can become quite large; and the power dissipation can increase by as much as a factor of five between 100 KHz and 10 MHz. The figure shows that, with no capacitive loading, the power increase with frequencies as high as 10 MHz is almost negligible. However, with large capacitive loads, more power is required.

The line receiver is designed to detect a zero crossing in the differential output of the line driver. Therefore, the propagation time of the driver is measured as the time difference between the application of a step input and the point where the differential output voltage crosses zero. A plot of the propagation time over temperature is shown in Figure 7. This delay is added directly to the propagation time of the transmission line and the delay of the line receiver to determine the total datapropagation time. However, in most cases, the delay of the driver is small, even by comparison to the uncertainties in the other delays.

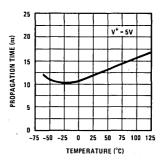


FIGURE 7. Propagation Time as a Function of Temperature

To summarize the characteristics of the DS7830 line driver, the input interfaces directly with standard TTL circuits. It presents a load which is equivalent to a fan out of 3 to the circuit driving it, and it operates from the 5.0V, ±10% logic supplies. The output can drive low impedance lines down to  $50\Omega$  and capacitive loads up to 5000 pF. The time skew between the outputs is minimized to reduce radiation from the twisted-pair lines, and the circuit is designed to clamp common mode transients coupled into the line. Short circuit protection is also provided. The integrated circuit consists of two independent drivers fabricated on a 41 x 53 mil-square die using the standard TTL process. A photomicrograph of the chip is shown in Figure 8.

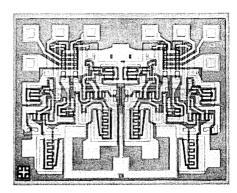


FIGURE 8. Photomicrograph of the DS7830 Dual Line Driver

#### LINE RECEIVER

As mentioned previously, the function of the line receiver is to convert the differential output signal of the line driver into a single ended, ground-referred signal to drive standard digital circuits on the receiving end. At the same time it must reject the common mode and induced noise on the transmission line.

Normally this would not be too difficult a task because of the large signal swings involved. However, it was considered important that the receiver operate from the +5V logic supply without requiring additional supply voltages, as do most other line receiver designs. This complicates the situation because the receiver must operate with ±15V input signals which are considerably greater than the operating supply voltage.

The large common mode range over which the circuit must work can be reduced with an attenuator on the input of the receiver. In this design, the input signal is attenuated by a factor of 30. Hence, the ±15V common mode voltage is reduced to ±0.5V, which can be handled easily by circuitry operating from a 5V supply. However, the differential input signal, which can go down as low as ±2.4V in the worst case, is also reduced to ±80 mV. Hence, it is necessary to employ a fairly accurate zero crossing detector in the receiver.

System requirements dictated that the threshold inaccuracy introduced by the zero crossing detector be less than 17 mV. In principle, this accuracy requirement should not pose insurmountable problems because it is a simple matter to make well matched parts in an integrated circuit.

Figure 9 shows a simplified schematic diagram of the circuit configuration used for the line receiver. The input signal is attenuated by the resistive dividers R1-R2 and R8-R3. This attenuated signal is fed into a balanced dc amplifier, operating in the common base configuration. This input amplifier, consisting of Q1 and Q2, removes the common mode component of the input signal. Further, it delivers an output signal at the collector of Q2, which is nearly equal in amplitude to the original differential input signal. This output signal is buffered by Q6 and drives an output amplifier, Q8. The output stage drives the logic load directly.

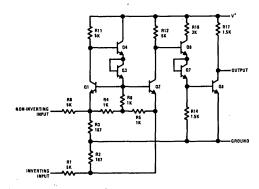


FIGURE 9. Simplified Schematic of the Line Receiver

An understanding of the circuit can be obtained by first considering the input stage. Assuming high current gains and neglecting the voltage drop across R3, the collector current of Q1 will be:

$$I_{C1} = \frac{V^{+} - V_{BE1} - V_{BE3} - V_{BE4}}{R11}.$$
 (1)

With equal emitter-base voltages for all transistors, this becomes:

$$I_{C1} = \frac{V^{+} - 3V_{BE}}{R11}$$
 (2)

The output voltage at the collector of Q2 will be:

$$V_{C2} = V^{+} - I_{C2}R12.$$
 (3)

When the differential input voltage to the receiver is zero, the voltages presented to the emitters of Q1 and Q2 will be equal. If Q1 and Q2 are matched devices, which is easy to arrange when they are fabricated close together on a single silicon chip, their collector currents will be equal with zero input voltage. Hence, the output voltage from Q2 can be determined by substituting (2) into (3):

$$V_{C2} = V^{+} - \frac{R12}{R11} (V^{+} - 3V_{BE}).$$
 (4)

For R11 = R12, this becomes:

 $V_{C2} = 3V_{BE}$ .

The voltage on the base of Q6 will likewise be  $3V_{BE}$  when the output is on the verge of switching from a zero to a one state. A differential input signal which causes Q2 to conduct more heavily will then make the output go high, while an input signal in the opposite direction will cause the output to saturate.

It should be noted that the balance of the circuit is not affected by absolute values of components—only by how well they match. Nor is it affected by variations in the positive supply voltage, so it will perform well with standard logic supply voltages between 4.5V and 5.5V. In addition, component values are chosen so that the collector currents of Q4 and Q6 are equal. As a result, the base currents of Q4 and Q6 do not upset the balance of the input stage. This means that circuit performance is not greatly affected by production or temperature variations in transistor current gain.

A complete schematic of the line receiver, shown in Figure 10, shows several refinements of the basic circuit which are needed to secure proper

operation under all conditions. For one, the explanation of the simplified circuit ignores the fact that the collector current of Q1 will be affected by common mode voltage developed across R3. This can give a 0.5V threshold error at the extremes of the ±15V common mode range. To compensate for this, a separate divider, R9 and R10, is used to maintain a constant collector current in Q1 with varying common mode signals. With an increasing common mode voltage on the non-inverting input, the voltage on the emitter of Q1 will increase. Normally, this would cause the voltage across R11 to decrease, reducing the collector current of Q1. However, the increasing common mode signal also drives the top end of R11 through R9 and R10 so as to hold the voltage drop across R11 constant.

In addition to improving the common mode rejection, R9 also forces the output of the receiver into the high state when nothing is connected to the input lines. This means that the output will be in a pre-determined state when the transmission cables are disconnected.

A diode connected transistor, Q5, is also added in the complete circuit to provide strobe capability. With a logic zero on the strobe terminal, the out-

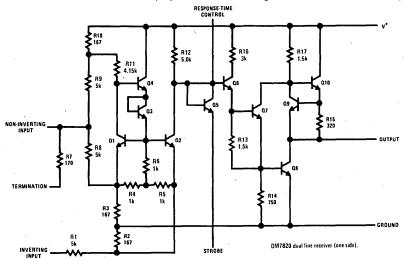


FIGURE 10. Complete Schematic of One Half of the DS7820 Line Receiver

put will be high no matter what the input signal is. With the strobe, the receiver can be made immune to any noise signals during intervals where no digital information is expected. The output state with the strobe on is also the same as the output state with the input terminals open.

The collector of Q2 is brought out so that an external capacitor can be used to slow down the receiver to where it will not respond to fast noise spikes. This capacitor, which is connected between the response-time-control terminal and ground, does not give exactly-symmetrical delays. The delay for input signals which produce a positive-going output will be less than for input signals of opposite polarity. This happens because the impedance on the collector of Q2 drops as Q6 goes into saturation, reducing the effectiveness of the capacitor.

Another difference in the complete circuit is that the output stage is improved both to provide more gain and to reduce the output resistance in the high output state. This was accomplished by adding Q9 and Q10. When the output stage is operating in the linear region, that is, on the verge of switching to either the high or the low state, Q9 and Q10 form sort of an active collector load for Q8. The current through R15 is constant at approximately 2 mA as the output voltage changes through the active region. Hence, the percentage change in the collector current of Q8 due to the voltage change across R17 is made smaller by this pre-bias current; and the effective stage gain is increased.

With the output in the high state (Q8 cut off), the output resistance is equal to R15, as long as the load current is less than 2 mA. When the load current goes above this value, Q9 turns on; and the output resistance increases to 1.5K, the value of R17.

This particular output configuration gives a higher gain than either a standard DTL or TTL output stage. It can also drive enough current in the high state to make it compatible with TTL, yet outputs can be wire OR'ed as with DTL.

Remaining details of the circuit are that Q7 is connected as an emitter follower to make the circuit even less sensitive to transistor current gains. R16 limits the base drive to Q7 with the output saturated, while R17 limits the base drive to the output transistor, Q8. A resistor, R7, which can be used to terminate the twisted-pair line is also included on the chip. It is not connected directly

across the inputs. Instead, one end is left open so that a capacitor can be inserted in series with the resistor. The capacitor significantly reduces the power dissipation in both the line transmitter and receiver, especially in low-duty-cycle applications, by terminating the line at high frequencies but blocking steady-state current flow in the terminating resistor.

Since line receivers are generally used repetitively in a system, the DS7820 has been designed with two independent receivers on a single silicon chip. The device is fabricated on a 41 x 49 mil-square die using the standard six mask planar-epitaxial process. The processing employed is identical to that used on TTL circuits, and the design does not impose any unusual demands on the processing. It is only required that various parts within the circuit match well, but this is easily accomplished in a monolithic integrated circuit without any special effort in manufacturing. A photomicrograph of the integrated circuit chip is shown in Figure 11.

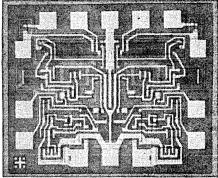


FIGURE 11. Photomicrograph of the DS7820 Dual Line

The only components in the circuit which see voltages higher than standard logic circuits are the resistors used to attenuate the input signal. These resistors, R1, R7, R8 and R9, are diffused into a separate, floating, N-type isolation tub, so that the higher voltage is not seen by any of the transistors. For a ±15V input voltage range, the breakdown voltages required for the collector-isolation and collector-base diodes are only 15V and 19V, respectively. These breakdown voltages can be achieved readily with standard digital processing.

The purpose of the foregoing was to provide some insight into circuit operation. A more exact mathematical analysis of the device is developed in Appendix A.

#### RECEIVER PERFORMANCE

The characteristics of the line receiver are described graphically in Figures 12 through 18. Figure 12 illustrates the effect of supply voltage variations on the threshold accuracy. The upper curve gives the differential input voltage required to hold the output at 2.5V while it is supplying  $200 \,\mu\text{A}$  to the digital load. The lower curve shows the differential input needed to hold the output at 0.4V while it sinks 3.5 mA from the digital load. This load corresponds to a worst case fanout of 2 with either DTL or TTL integrated circuits. The data shows that the threshold accuracy is only affected by ±60 mV for a ±10% change in supply voltage. Proper operation can be secured over a wider range of supply voltages, although the error becomes excessive at voltages below 4V.

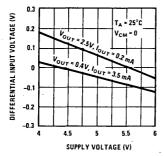


FIGURE 12. Differential Input Voltage Required for High or Low Output as a Function of Supply Voltage

Figure 13 is a similar plot for varying common mode input voltage. Again the differential input voltages are given for high and low states on the output with a worst case fanout of 2. With precisely matched components within the integrated circuit, the threshold voltage will not

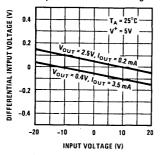


FIGURE 13. Differential Input Voltage Required for High or Low Output as a Function of Common Mode Voltage

change with common mode voltage. The mismatches typically encountered give a threshold voltage change of  $\pm 100~\text{mV}$  over a  $\pm 20\text{V}$  common mode range. This change can have either a positive slope or a negative slope.

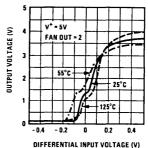


FIGURE 14. Voltage Transfer Function

The transfer function of the circuit is given in Figure 14. The loading is for a worst case fanout of 2. The digital load is not linear, and this is reflected as a non-linearity in the transfer function which occurs with the output around 1.5V. These transfer characteristics show that the only significant effect of temperature is a reduction in the positive swing at -55°C. However, the voltage available remains well above the 2.5V required by digital logic.

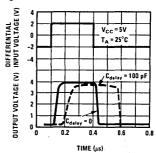


FIGURE 15. Response Time With and Without an External Delay Capacitor

Figure 15 gives the response time, or propagation delay, of the receiver. Normally, the delay through the circuit is about 40 ns. As shown, the delay can be increased, by the addition of a capacitor between the response-time terminal and ground, to make the device immune to fast noise spikes on the input. The delay will generally be longer for negative going outputs than for positive going outputs.

Under normal conditions, the power dissipated in the receiver is relatively low. However, with large common mode input voltages, dissipation increases markedly, as shown in Figure 16. This is of little consequence with common mode transients, but the increased dissipation must be taken into account when there is a dc difference between the grounds of the transmitter and the receiver. It is important to note that Figure 16 gives the dissipation for one half the dual receiver. The total package dissipation will be twice the values given when both sides are operated under identical conditions.

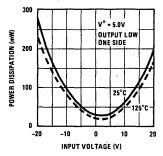


FIGURE 16. Internal Power Dissipation as a Function of Common Mode Input Voltage

Figure 17 shows that the power supply current also changes with common mode input voltage due to the current drawn out of or fed into the supply through R9. The supply current reaches a maximum with negative input voltages and can actually reverse with large positive input voltages. The figure also shows that the supply current with the output switched into the low state is about 3 mA higher than with a high output.

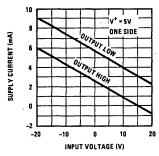


FIGURE 17. Power Supply Current as a Function of Common Mode Input Voltage

The variation of the internal termination resistance with temperature is illustrated in Figure 18. Taking into account the initial tolerance as well as the change with temperature, the termination resistance is by no means precise. Fortunately, in most cases, the termination resistance can vary appreciably without greatly affecting the characteristics of the transmission line. If the resistor tolerance is a problem, however, an external resistor can be used in place of the one provided within the integrated circuit.

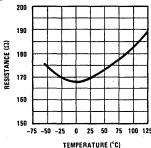


FIGURE 18. Variation of Termination Resistance With Temperature

#### DATA TRANSMISSION

The interconnection of the DS7830 line driver with the DS7820 line receiver is shown in Figure 19. With the exception of the transmission line, the design is rather straightforward. Connections on the input of the driver and the output or strobe of the receiver follow standard design rules for DTL or TTL integrated logic circuits. The load presented by the driver inputs is equal to 3 standard digital loads, while the receiver can drive a worst-case fanout of 2. The load presented by the receiver strobe is equal to one standard load.

The purpose of C1 on the receiver is to provide do isolation of the termination resistor for the transmission line. This capacitor can both increase the differential noise immunity, by reducing attenuation on the line, and reduce power dissipation in both the transmitter and receiver. In some applications, C1 can be replaced with a short between Pins 1 and 2, which connects the internal termination resistor of the DS7820 directly across the line. C2 may be included, if necessary, to control the response time of the receiver, making it immune to noise spikes that may be coupled differentially into the transmission lines.

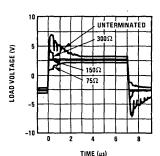


FIGURE 20. Transmission Line Response With Various Termination Resistances

The effect of termination mismatches on the transmission line is shown in Figure 20. The line was constructed of a twisted pair of No. 22 copper conductors with a characteristic impedance of approximately 17002. The line length was about 150 ns and it was driven directly from a DS7830 line driver. The data shows that termination resistances which are a factor of two off the nominal value do not cause significant reflections on the line. The lower termination resistors do, however, increase the attenuation.

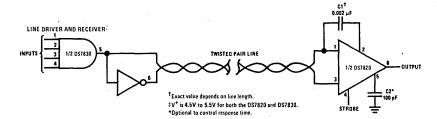


FIGURE 19. Interconnection of the Line Driver and Line Receiver

Figure 21 gives the line-transmission characteristics with various termination resistances when a dc isolation capacitor is used. The line is identical to that used in the previous example. It can be seen that the transient response is nearly the same as a dc terminated line. The attenuation, on the other hand, is considerably lower, being the same as an unterminated line. An added advantage of using the isolation capacitor is that the dc signal current is blocked from the termination resistor which reduces the average power drain of the driver and the power dissipation in both the driver and receiver.

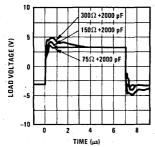


FIGURE 21. Line Response for Various Termination Resistances With a DC Isolation Capacitor

The effect of different values of dc isolation capacitors is illustrated in Figure 22. This shows that the RC time constant of the termination resistor/isolation capacitor combination should be 2 to 3 times the line delay. As before, this data was taken for a 150 ns long line.

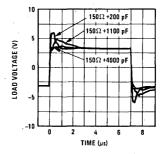


FIGURE 22. Response of Terminated Line With Different DC Isolation Capacitors

In Figure 23, the influence of a varying ground voltage between the transmitter and the receiver is shown. The difference in the characteristics arises because the source resistance of the driver is not constant under all conditions. The high output of

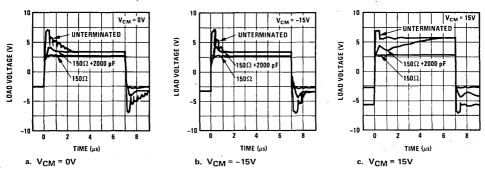


FIGURE 23. Line Response With Different Terminations and Common Mode Input Voltages

the transmitter looks like an open circuit to voltages reflected from the receiving end of the transmission line which try to drive it higher than its normal dc state. This condition exists until the voltage at the transmitting end becomes high enough to forward bias the clamp diode on the 5V supply. Much of the phenomena which does not follow simple transmission-line theory is caused by this. For example, with an unterminated line, the overshoot comes from the reflected signal charging the line capacitance to where the clamp diodes are forward biased. The overshoot then decays at a rate determined by the total line capacitance and the input resistance of the receiver.

When the ground on the receiver is 15V more negative than the ground at the transmitting end, the decay with an unterminated line is faster, as shown in Figure 23b. This occurs because there is more current from the input resistor of the receiver to discharge the line capacitance. With a terminated line, however, the transmission characteristics are the same as for equal ground voltages because the terminating resistor keeps the line from getting charged.

Figure 23c gives the transmission characteristics when the receiver ground is 15V more positive than the transmitter ground. When the line is not terminated, the differential voltage swing is increased because the high output of the driver will be pulled against the clamp diodes by the common mode input current of the receiver. With a dc isolation capacitor, the differential swing will reach this same value with a time constant determined by the isolation capacitor and the input resistance of the receiver. With a dc coupled termination, the characteristics are unchanged because the differential load current is large by comparison to the common mode current so that the output transistors of the driver are always conducting.

The low output of the driver can also be pulled below ground to where the lower clamp diode conducts, giving effects which are similar to those described for the high output. However, a current of about 9 mA is required to do this, so it does not happen under normal operating conditions.

To summarize, the best termination is an RC combination with a time constant approximately equal to 3 times the transmission-line delay. Even though its value is not precisely determined, the internal termination resistor of the integrated circuit can be used because the line characteristics are not greatly affected by the termination resistor.

The only place that an RC termination can cause problems is when the data transmission rate approaches the line delay and the attenuation down the line (terminated) is greater than 3 dB. This would correspond to more than 1000 ft. of twisted-pair cable with No. 22 copper conductors. Under these conditions, the noise margin can disappear with low-duty-cycle signals. If this is the case, it is best to operate the twisted-pair line without a termination to minimize transmission losses. Reflections should not be a problem as they will be absorbed by the line losses.

#### CONCLUSION

A method of transmitting digital information in high-noise environments has been described. The technique is a much more attractive solution than high-noise-immunity logic as it has lower power consumption, provides more noise rejection, operates from standard 5V supplies, and is fully compatible with almost all integrated logic circuits. An additional advantage is that the circuits can be fabricated with integrated circuit processes used for standard logic circuits.

#### APPENDIX A

#### LINE RECEIVER

**Design Analysis** 

The purpose of this appendix is to derive mathematical expressions describing the operation of the line receiver. It will be shown that the performance of the circuit is not greatly affected by the absolute value of the components within the integrated circuit or by the supply voltage. Instead, it depends mostly on how well the various parts match.

The analysis will assume that all the resistors are well matched in ratio and that the transistors are likewise matched, since this is easily accomplished over a broad temperature range with monolithic construction. However, the effects of component mismatching will be discussed where important. Further, large transistor current gains will be assumed, but it will be pointed out later that this is valid for current gains greater than about 10.

A schematic diagram of the DS7820 line receiver is shown in Figure A-1. Referring to this circuit, the collector current of the input transistor is given by

$$\begin{split} I_{C1} &= \frac{V^{+} - V_{BE1} - V_{BE3} - V_{BE4}}{R9 \ / \ R10 + R11 + R3 \ / \ R8} \\ &= \frac{R3}{R4 + 2R6 + R3} \ V_{BE1} - \frac{R3 \ / \ R11}{R8 + R3 \ / \ R1} V_{IN} \\ &= \frac{R9 \ / \ R10 + R11 + R3 \ / \ R8}{(V_{IN} - V^{+}) \ \frac{R10 \ / \ R11}{R9 + R10 \ / \ R11}} \\ &+ \frac{R9 \ / \ R10 + R11 + R3 \ / \ R8}{R9 \ / \ R10 + R11 + R3 \ / \ R8} \end{split} \tag{A. 1}$$

where  $V_{IN}$  is the common mode input voltage and  $R_a//R_b$  denotes the parallel connection of the two resistors. In Equation (A. 1), R8 = R9, R3 = R10, R10 << R11, R9 >> R10, R3 << R11, R8 >> R3

and 
$$\frac{R3}{R4 + 2R6 + R3}$$
 <<3 so it can be reduced to

$$I_{C1} = \frac{V^{+} - 3V_{BE} - \frac{R10}{R9} V^{+}}{R10 + R11 + R3}$$
 (A. 2)

which shows that the collector current of Q1 is not affected by the common mode voltage.

The output voltage on the collector of Q2 is

$$V_{C2} = V^{+} - I_{C2}R12$$
 (A. 3)

For zero differential input voltage, the collector currents of Q1 and Q2 will be equal so Equation (A. 3) becomes

$$V_{C2} = V^{+} - \frac{R12 \left(V^{+} - 3V_{BE} - \frac{R10}{R9} V^{+}\right)}{R10 + R11 + R3}$$
. (A. 4)

It is desired that this voltage be  $3V_{BE}$  so that the output stage is just on the verge of switching with zero input. Forcing this condition and solving for R12 yields

R12 yields  
R12 = (R10 + R11 + R3) 
$$\frac{V^+ - 3V_{BE}}{V^+ - 3V_{BE} - \frac{R10}{R9}} V^+$$

(A. 5)

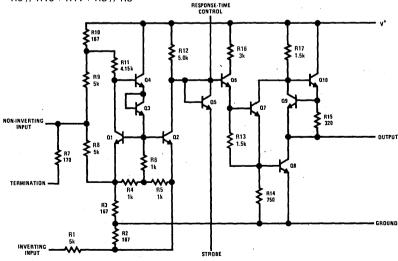


FIGURE A-1. Schematic Diagram of One Half of the DS7820 Line Receiver

This shows that the optimum value of R12 is dependent on supply voltage. For a 5V supply it has a value of 4.7 k $\Omega$ . Substituting this and the other component values into (A. 4),

$$V_{C2} = 2.83V_{BE} + 0.081V^{+},$$
 (A. 6)

which shows that the voltage on the collector of Q2 will vary by about 80 mV for a 1V change in supply voltage.

The next step in the analysis is to obtain an expression for the voltage gain of the input stage.

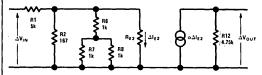


FIGURE A-2. Equivalent Circuit Used to Calculate Input Stage Gain

An equivalent circuit of the input stage is given in Figure A-2. Noting that R6 = R7 = R8 and  $R2 \cong 0.1$  (R6 + R7//R8), the change in the emitter current of Q1 for a change in input voltage is

$$\Delta I_{E2} = \frac{0.9 \text{ R2}}{\text{R1 (0.9 R2 + R}_{E2})} \Delta V_{IN}$$
 (A. 7)

Hence, the change in output voltage will be

$$\begin{split} \Delta V_{OUT} &= & \alpha I_{E2}R12 \\ &= \frac{0.9 \ \alpha \ R2 \ R12}{R1 \ (0.9 \ R2 + R_{E2})} \ \Delta V_{IN} \ . \end{split} \tag{A. 8}$$

Since  $\alpha \cong 1$ , the voltage gain is

$$A_{V1} = \frac{0.9 \text{ R2 R12}}{\text{R1 (0.9 R2 + R}_{\text{E2}})}$$
 (A. 9)

The emitter resistance of Q2 is given by

$$R_{E2} = \frac{kT}{q!_{C2}}$$
, (A. 10)

$$I_{C2} = \frac{V^+ - 3V_{BE}}{R12}$$
 (A. 11)

$$I_{C2} = \frac{V^{+} - 3V_{BE}}{R12}$$
 (A. 11)  
 $R_{E2} = \frac{kTR12}{q(V^{+} - 3V_{BE})}$  (A. 12)

Therefore, at  $25^{\circ}$ C where  $V_{BE} = 670 \text{ mV}$  and kT/q = 26 mV, the computed value for gain is 0,745. The gain is not greatly affected by temperature as the gain at  $-55^{\circ}$ C where  $V_{BF} = 810 \text{ mV}$ and kT/q = 18 mV is 0.774, and the gain at 125°C where  $V_{BE} = 480 \text{ mV}$  and kT/q = 34 mV is 0.730.

With a voltage gain of 0.75, the results of Equation (A. 6) show that the input referred threshold voltage will change by 0.11V for a 1V change in supply voltage. With the standard ±10-percent supplies used for logic circuits, this means that the threshold voltage will change by less than ±60 mV.

Finally, the threshold error due to finite gain in the output stage can be considered. The collector current of Q7 from the bleeder resistor R14, is large by comparison to the base current of Q8, if Q8 has a reasonable current gain. Hence, the collector current of Q7 does not change appreciably when the output switches from a logic one to a logic zero. This is even more true for Q6, an emitter follower which drives Q7. Therefore, it is safe to presume that Q6 does not load the output of the first-stage amplifier, because of the compounded current gain of the three transistors, and that Q8 is driven from a low resistance source.

It follows that the gain of the output stage can be determined from the change in the emitter-base voltage of Q8 required to swing the output from a logic one state to a logic zero state. The expression

$$\Delta V_{BE} = \frac{kT}{q} \log_e \frac{I_{C1}}{I_{C2}}$$
 (A. 13)

describes the change in emitter-base voltage required to vary the collector current from one value, I<sub>C1</sub>, to a second, I<sub>C2</sub>. With the output of the receiver in the low state, the collector current

$$\begin{split} I_{OL} &= \frac{V^{+} - V_{OL} - V_{BE9} - V_{BE10}}{R17} \\ &+ \frac{V_{BE9}}{R15} - \frac{V_{BE8}}{R14} + \frac{V_{BE7}}{R13} + I_{SINK} , \end{split} \tag{A. 14}$$

where  $V_{\text{OL}}$  is the low state output voltage and ISINK is the current load from the logic that the receiver is driving. Noting that R13 = 2R14 and figuring that all the emitter-base voltages are the same, this becomes

$$I_{OL} = \frac{V^{+} - V_{OL} - 2V_{BE}}{R17} + \frac{V_{BE}}{R15} - \frac{V_{BE}}{2R14} + I_{SINK}.$$
 (A. 15)

Similarly, with the output in the high state, the collector current of Q8 is

$$I_{OH} = \frac{V^{+} - V_{OH} - V_{BE9} - V_{BE10}}{R17} + \frac{V_{BE9}}{R15} - \frac{V_{BE8}}{R14}$$

$$+\frac{V_{BE7}}{R13}-I_{SOURCE}, \qquad (A. 16)$$

where VoH is the high-level output voltage and ISOURCE is the current needed to supply the input leakage of the digital circuits loading the comparator.

With the same conditions used in arriving at (A. 15), this becomes

$$I_{OH} = \frac{V^{+} - V_{OH} - 2V_{BE}}{R17} + \frac{V_{BE}}{R15}$$
$$- \frac{V_{BE}}{2R14} - I_{SOURCE}.$$

From (A. 13) the change in the emitter-base voltage of Q8 in going from the high output level to the low output level is

(A. 17)

$$\Delta V_{BE} = \frac{kT}{q} \log_e \frac{I_{OL}}{I_{OH}}$$
 (A. 18)

providing that Q8 is not quite in saturation, although it may be on the verge of saturation.

The change of input threshold voltage is then

$$\Delta V_{TH} = \frac{kT}{qA_{V1}} \log_e \frac{I_{OL}}{I_{OH}}$$
 (A. 19)

where  $A_{V1}$  is the input stage gain. With a worst case fanout of 2, where  $V_{OH}=2.5 \text{V}, V_{OL}=0.4 \text{V}, I_{\text{SOURCE}}=40~\mu\text{A}$  and  $I_{\text{SINK}}=3.2$  mA, the calculated change in threshold is 37 mV at 25°C, 24 mV at  $-55^{\circ}\text{C}$  and 52 mV at  $125^{\circ}\text{C}$ .

The measured values of overall gain differ by about a factor of two from the calculated gain. This is not too surprising because a number of assumptions were made which introduce small errors, and all these errors lower the gain. It is also not too important because the gain is high enough where another factor of two reduction would not cause the circuit to stop working.

The main contributors to this discrepancy are the non-ideal behavior of the emitter-base voltage of Q8 due to current crowding under the emitter and the variation in the emitter base voltage of Q7 and Q8 with changes in collector-emitter voltage (h<sub>RE</sub>).

Although these parameters can vary considerably with different manufacturing methods, they are relatively fixed for a given process. The  $\Delta V_{\rm BE}$  errors introduced by these quantities, if known, can be added directly into Equation (A. 18) to give a more accurate gain expression.

The most stringent matching requirement in the receiver is the matching of the input stage divider resistors: R1 with R8 and R2 with R3. As little as 1% mismatch in one of these pairs can cause a threshold shift of 150 mV at the extremes of the ±15V common mode range, Because of this, it is necessary to make the resistors absolutely identical and locate them close together. In addition, since R1 and R8 do dissipate a reasonable amount of power, they have to be located to minimize the thermal gradient between them. To do this, R9 was located between R1 and R8 so that it would heat both of these resistors equally. There are not serious heating problems with R2 and R3; however, because of their low resistance value, it was necessary even to match the lengths of the aluminum interconnects, as the resistance of the aluminum is high enough to cause intolerable mismatches. Of secondary importance is the matching of Q1 and Q2 and the matching of ratios between R11 and R12. A 1 mV difference in the emitterbase voltages of Q1 and Q2 causes a 30 mV input offset voltage as does a 1% mismatch in the ratio of R11 to R12.

The circuit is indeed insensitive to transistor current gains as long as they are above 10. The collector currents of Q4 and Q6 are made equal so that their base currents load the collectors of Q1 and Q2 equally. Hence, the input threshold voltage is affected only by how well the current gains match. Low current gain in the output transistor, Q8, can cause a reduction in gain. But even with a current gain of 10, the error produced in the input threshold voltage is less than 50 mV.

# **Transmission Line Characteristics**

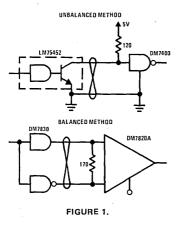
National Semiconductor Bill Fowler May 1974



#### INTRODUCTION

Digital systems generally require the transmission of digital signals to and from other elements of the system. The component wavelengths of the digital signals will usually be shorter than the electrical length of the cable used to connect the subsystems together and, therefore, the cables should be treated as a transmissions line. In addition, the digital signal is usually exposed to hostile electrical noise source which will require more noise immunity then required in the individual subsystems environment.

The requirements for transmission line techniques and noise immunity are recognized by the designers of subsystems and systems, but the solution used vary considerably. Two widely used example methods of the solution are shown in Figure 1. The two methods



illustrated use unbalanced and balanced circuit techniques. This application note will delineate the characteristics of digital signals in transmission lines and characteristics of the line that effect the quality, and will compare the unbalanced and balanced circuits performance in digital systems.

#### NOISE

The cables used to transmit digital signals external to a subsystem and in route between the subsystem, are exposed to external electromagnetic noise caused by

switching transients from actuating devices of neighboring control systems. Also external to a specific subsystem, another subsystem may have a ground problem which will induce noise on the system, as indicated in Figure 2.

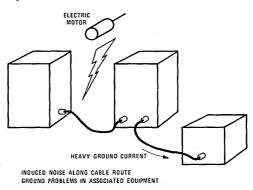


FIGURE 2. External Noise Sources

The signals in adjacent wires inside a cable may induce electromagnetic noise on other wires in the cable. The induced electromagnetic noise is worse when a line terminated at one end of the cable is near to a driver at the same end, as shown in Figure 3. Some noise may be

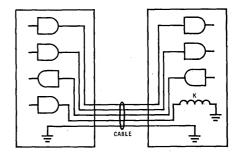


FIGURE 3. Internal Noise Sources

induced from relay circuits which have very large transient voltage swings compared to the digital signals in the same cable. Another source of induced noise is current in the common ground wire or wires in the cable.

#### DISTORTION

The objective is the transmission and recovery of digital intelligence between subsystems, and to this end, the characteristics of the data recovered must resemble the data transmitted. In *Figure 4* there is a difference in the pulse width of the data and timing signal transmitted, and the corresponding signal received. In addition there is a further difference in the signal when the data is "AND"ed with the timing signal. The distortion of the signal occurred in the transmission line and in the line driver and receiver.

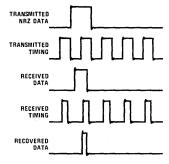


FIGURE 4. Effect of Distortion

A primary cause of distortion is the effect the transmission line has on the rise time of the transmitted data. Figure 5 shows what happens to a voltage step from the driver as it travels down the line. The rise time of the signal increases as the signal travels down the line. This effect will tend to affect the timing of the recovered signal.

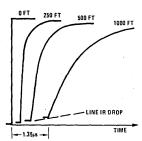


FIGURE 5. Signal Response at Receiver

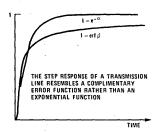


FIGURE 6. Signal Rise Time

The rise time in a transmission line is not an exponential function but a complementary error function. The high frequency components of the step input are attenuated and delayed more than the low frequency components. This attenuation is inversely proportional to the frequency. Notice in *Figure 6* particularly that the signal takes much longer to reach its final dc value. This effect is more significant for fast risetimes.

The Duty Cycle of the transmitted signal also causes distortion. The effect is related to the signal rise time as shown in *Figure 7*. The signal doesn't reach one logic level before the signal changes to another level. If the signal has a 1/2 (50%) Duty Cycle and the threshold of the receiver is halfway between the logic levels, the distortion is small. But if the Duty Cycle is 1/8 as shown in the second case the signal is considerably distorted. In some cases, the signal may not reach the receiver threshold at all.

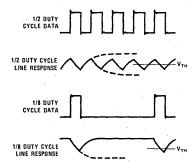


FIGURE 7. Signal Distortion Due to Duty Cycle

In the previous example, it was assumed that the threshold of the receiver was halfway between the ONE and ZERO logic levels. If the receiver threshold isn't halfway the receiver will contribute to the distortion of the recovered signal. As shown in *Figure 8*, the pulse time is lengthened or shortened, depending on the polarity of the signal at the receiver. This is due to the offset of the receiver threshold.

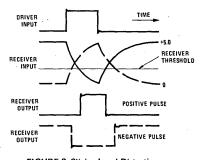


FIGURE 8. Slicing Level Distortion

#### **UNBALANCED METHOD**

Another source of distortion is caused by the IR losses in the wire. *Figure 9* shows the IR losses that occur in a thousand feet of no. 22 AWG wire. Notice in this

example that the losses reduce the signal below the threshold of the receiver in the unbalanced method. Also that part of the IR drop in the ground wire is common to other circuits—this ground signal will appear as a source of noise to the other unbalanced line receivers in the system.

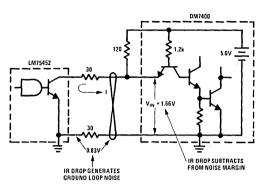


FIGURE 9. Unbalanced Method

Transmission lines don't necessarily have to be perfectly terminated at both ends, (as will be shown later) but the termination used in the unbalanced method will cause additional distortion. Figure 10 shows the signal on the transmission line at the driver and at the receiver. In this case the receiver was terminated in  $120\Omega_{\rm c}$  but the characteristic impedance of the line is much less. Notice that the wave forms have significant steps due to the incorrect termination of the line. The signal is subject to misinterpretation by the line receiver during the period of this signal transient because of the distortion caused by Duty Cycle and attenuation. In addition, the noise margin of the signal is reduced.

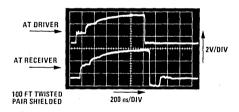


FIGURE 10. LM75451, DM7400 Line Voltage Waveforms

The signal waveforms on the transmission line can be estimated before hand by a reflection diagram. Figure 11 shows the reflection diagram of the rise time wave forms. The voltage versus current plot on left is used to predict the transient rise time of the signal shown on the right. The initial condition on the transmission line is an IR drop across the line termination. The first transient on the line traverses from this initial point to zero current. The path it follows corresponds to the characteristic impedance of the line. The second transient on the diagram is at the line termination. As shown, the signal reflects back and forth until it reaches its final dc value.

Figure 12 shows the reflection diagram of the fall time. Again the signal reflects back and forth between the line

termination until it reaches its final dc value. In both the rise and fall time diagrams, there are transient voltage and current signals that subtract from the particular signal and add to the system noise.

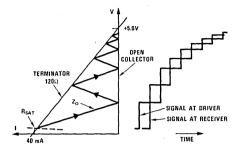


FIGURE 11. Line Reflection Diagram of Rise Time

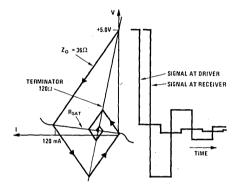
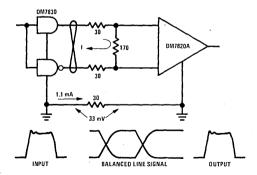


FIGURE 12. Line Reflection Diagram of Fall Time

#### **BALANCED METHOD**

In the balanced method shown in Figure 13, the transient voltages and currents on the line are equal and



THE GROUND LOOP CURRENT IS MUCH LESS THAN SIGNAL CURRENT

#### FIGURE 13. Cross Talk of Signals

opposite and cancel each others noise. Also unlike the unbalanced method, they generate very little ground noise. As a result, the balanced circuit doesn't contribute to the noise pollution of its environment.

The circuit used for a line receiver in the balanced method is a differential amplifier. Figure 14 shows a noise transient induced equally on line A and line B from line C. Because the signals on line A and B are equal, the signals are ignored by the differential line receiver.

Likewise for the same reason, the differential signals on line A and B from the driver will not induce transients on line C. Thus, the balanced method doesn't generate noise and also isn't susceptible to noise. On the other hand the unbalanced method is more sensitive to noise and also generates more noise.

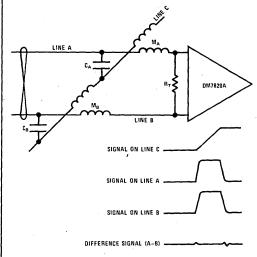


FIGURE 14. Cross Talk of Signals

The characteristic impedance of the unbalanced transmission line is less than the impedance of the balanced transmission line. In the unbalanced method there is more capacitance and less inductance than in the balanced method. In the balance method the Reactance to adjacent wires is almost cancelled (see Figure 15). As a result a transmission line may have a  $60\Omega$  unbalanced impedance and a  $90\Omega$  balanced impedance. This means that the unbalanced method, which is more susceptible to IR drop, must use a smaller value termination, which will further increase the IR drop in the line.

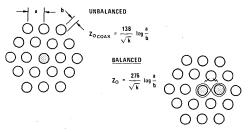


FIGURE 15. ZO Unbalanced < ZO Balanced

The impedance measurement of an unbalance and balance line must be made differently. The balanced impedance must be measured with a balanced signal. If there is any unbalance in the signal on the balanced line, there will be

an unbalance reflection at the terminator. Therefore, the lines should also be terminated for unbalanced signals. Figure 16 shows the perfect termination configuration of a balanced transmission line. This termination method is primarily required for accurate impedance measurements.

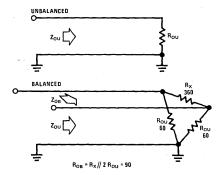


FIGURE 16. Impedance Measurement

#### **MEASURED PERFORMANCE**

The unbalanced method circuit used in this application note up to this point is the unbalanced circuit shown in Figure 1. The termination of its transmission line was greater than the characteristic impedance of the unbalanced line and the circuit had considerable threshold offset. The measured performance of the unbalanced circuit wasn't comparable to the balanced method. Therefore, for the following comparison of unbalanced and balanced circuits, an improved termination shown in Figure 17 will be used. This circuit terminates the line in  $60\Omega$  and minimized the receiver threshold offset.

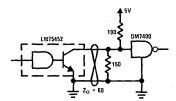


FIGURE 17. Improved Unbalanced Method

A plot of the Absolute Maximum Data Rate versus cable type is shown in *Figure 18*. The graph shows the different performances of the DM7820A line receiver and

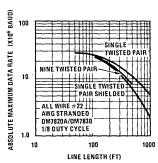
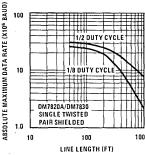


FIGURE 18. Data Rate vs Cable Type





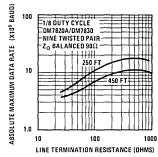


FIGURE 20. Data Rate vs Line Termination

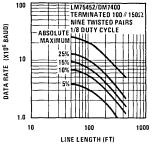


FIGURE 21. Data Rate vs Distorion of LM75452, DM7400

the DM7830 line driver circuits with a worse case 1/8 Duty Cycle in no. 22 AWG stranded wire cables. In a single twisted pair cable there is less reactance than in a cable having nine twisted pairs and in turn this cable has less reactance than shielded pairs. The line length is reduced in proportion to the increased line attenuation which is proportional to the line reactance. The plot shows that the reactance and attenuation has a significant effect on the cable length. Absolute Maximum Data Rate is defined as the Data Rate at which the output of the line receiver is starting to be degraded. The roll off of the performance above 20 mega baud is due to the circuit switching response limitation.

Figure 19 shows the reduction in Data Rate caused by Duty Cycle. It can be observed that the Absolute Maximum Duty Rate of 1/8 Duty Cycle is less than 1/2 Duty Cycle. The following performance curves will use 1/8 Duty Cycle since it is the worst case.

Absolute Maximum Duty Rate versus the Line Termination Resistance for two different lengths of cable is shown in *Figure 20*. It can be seen from the figure that the termination doesn't have to be perfect in the case of balanced circuits. It is better to have a termination resistor to minimize the extra transient signal reflecting between the ends of the line. The reason the Data Rate increases with increased Termination Resistance is that there is less IR drop in the cable.

The graphs in *Figure 21* shows the Data Rate versus the Line Length for various percentage of timing distortion using the unbalanced LM75452 and DM7400 circuits shown in *Figure 17*. The definition of Timing Distortion

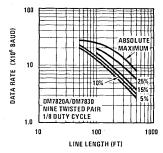


FIGURE 22. Data Rate vs Distorion of DM7820A, DM7830

is the percentage difference in the pulse width of the data sent versus the data received.

Data Rate versus the Line Length for various percentage of timing distorition using the balanced DM7820A and DM7830 circuit is shown in *Figure 22*. The distortion of this method is improved over the unbalanced method, as was previously theorized.

The Absolute Maximum Data Rate versus Line Lengths shown in the previous two figures didn't include any induced signal noise. *Figure 23* shows the test configuration of the unbalanced circuits which was used to

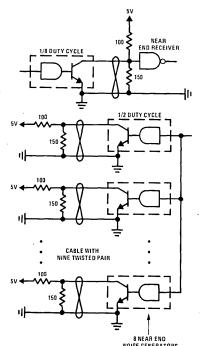


FIGURE 23. Signal Cross Talk Experiment Using DM75452, DM7400

measure near end cross talk noise. In this configuration there are eight line drivers and one receiver at one end of the cable. The performance of the receiver measured in the presence of the driver noise is shown in *Figure 24*.

Figure 24 shows the Absolute Maximum Duty Rate of the unbalanced method versus line length and versus the number of line drivers corresponding to the test configuration delineated in Figure 23. In the noise measurement set-up there was a ground return for each signal wire. If there is only one ground return in the cable the performance is worse. The graph shows that the effective line length is drastically reduced as additional Near End Drivers are added. When this performance is compounded by timing distortion the performance is further reduced.

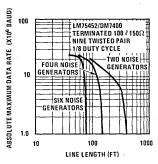


FIGURE 24. Data Rate vs Signal Cross Talk of LM75452, DM7400

Figure 25 shows the test configuration of the balanced circuit used to generate worst case Near End cross talk

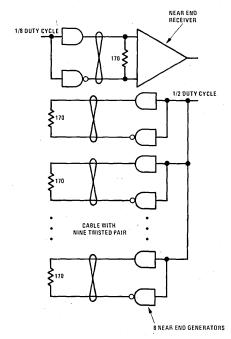


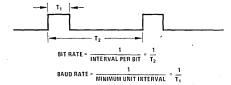
FIGURE 25. Signal Cross Talk Experiment Using DM7830, DM7820A

noise similar to the unbalance performance shown in the previous figure. Unlike the unbalanced case, there was no measurable degradation of the circuits Data Rate or distortion.

#### CONCLUSION

National has a full line of both Balanced and Unbalanced Line Drivers and Receivers. Both circuit types work well when used within their limitations. This application note shows that the balanced method is preferable for long lines in noisy electrical evironments. On the other hand the unbalanced circuit works perfectly well with shorter lines and reduced data rates. It should be kept in mind that when you are spending \$500,000 for a CPU and \$75,000 for peripherals, it pays to investigate the best way to transmit data between them.

#### **DEFINITION OF BAUD RATE**



The data in this note was plotted versus Baud Rate. The minimum unit interval reflected the worse case conditions and also normalized the diagrams so that the diagrams were independent of duty cycle. If the duty cycle is 50% then the Baud Rate is twice the Bit Rate.

#### REFERENCES

IC's for Digital Data Transmission, Widlar and Kubinec, National Semiconductor Application Note AN-22.

Data Bus and Differential Line Drivers and Receivers, Richard Percival, *National Semiconductor Application Note AN-83*.

RADC TR73-309, Experimental Analysis of the Transmission of Digital Signals over Twisted Pair Cable, Hendrickson and Evanowski, *Digital Communication Section Communications and Navigation Division*, Rome Air Development Center, Griffis Air Force Base, New York.

Fast Pulse Techniques, Thad Dreher, E-H Research Laboratories, Inc., The Electronic Engineer, Aug. 1969.

Transient Analysis of Coaxial Cables, Considering Skin Effects, Wigingtom and Nahmaj, *Proceedings of the IRE*, Feb. 1957.

Reflection and Crosstalk in Logic, Circuit Interconnections, John DeFalco, Honeywell, Inc., *IEEE Spectrum*, July 1970.

# Transmission Line Drivers and Receivers for EIA Standards RS-422 and RS-423

National Semiconductor Application Note 214 John Abbott October 1978



With the advent of the microprocessor, logic designs have become both sophisticated and modular in concept. Frequently the modules making up the system are very closely coupled on a single printed circuit board or cardfile. In a majority of these cases a standard bus transceiver will be adequate. However because of the distributed intelligence ability of the microprocessor, it is becoming common practice for the peripheral circuits to be physically separated from the host processor with data communications being handled over cables (e.g. plant environmental control or security system). And often these cables are measured in hundreds or thousands of feet as opposed to inches on a backplane. At this point the component wavelengths of the digital signals may become shorter than the electrical length of the cable and consequently must be treated as transmission lines. Further, these signals are exposed to electrical noise sources which may require greater noise immunity than the single chassis system.

It is the object of this application note to underscore the more important design requirements for balanced and unbalanced transmission lines, and to show that National's DS1691 driver and DS78LS120 receiver meet or exceed all of those requirements.

#### THE REQUIREMENTS

The requirements for transmission lines and noise immunity have been adequately recognized by National

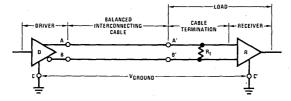
Semiconductor's application note AN-108 and E.I.A. standards RS-422 (balanced) and RS-423 (unbalanced). A summary review of these notes will show that the controlling factors in a voltage digital interface are:

- 1) The cable length
- 2) The modulation rate
- 3) The characteristic of the interconnection cable
- 4) The rise time of the signal

RS-422 and RS-423 contain several useful guidelines relative to the choice of balanced circuits versus unbalanced circuits. *Figures 1a and 1b* are the digital interface for balanced (1a) and unbalanced (1b) circuits.

Even though the unbalanced interface circuit is intended for use at lower modulation rates than the balanced circuit, its use is not recommended where the following conditions exist:

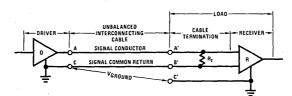
- The interconnecting cable is exposed to noise sources which may cause a voltage sufficient to indicate a change of binary state at the load.
- 2) It is necessary to minimize interference with other signals, such as data versus clock.
- 3) The interconnecting cable is too long electrically for unbalanced operation (Figure 2)



Legend:

 $R_{t}$  = Optional cable termination resistance/receiver input impedance. VGROUND = Ground potential difference A. B = Driver interface. A', B' = Load interface C = Driver circuit ground C' = Load circuit ground

FIGURE 1a. RS-422 Balanced Digital Interface Circuit



Legend:

 ${
m R_1}$  = Transmission line termination and/or receiver input impedance VGROUND = Ground potential difference A, C = Driver interface

A', B' = Load interface C = Driver circuit ground C' = Load circuit ground

FIGURE 1b. RS-423 Unbalanced Digital Interface Circuit

#### **CABLE LENGTH**

While there is no maximum cable length specified, guidelines are given with respect to conservative operating distances as a function of modulation rate. Figure 2 is a composite of the guidelines provided by RS-422 and RS-423 for data modulation versus cable length. The data is for 24 AWG twisted pair cable terminated for worst case (due to IR drop) in a 100 Ohm load, with rise and fall times equal to or less than one half unit interval at the applied modulation rate.

The maximum cable length between driver and load is a function of the baud rate. But it is influenced by:

- 1) A maximum common noise range of ±7 volts
  - A) The amount of common-mode noise
     Difference of driver and receiver ground potential plus driver offset voltage and coupled
  - B) Ground potential differences between driver and load.
  - C) Cable balance
    Differential noise caused by imbalance between the signal conductor and the common return (ground)
- Cable termination
   At rates above 200 kilobaud or where the rise time is 4 times the one way propagation delay time of the cable (RS-422 Sec 7.1.2)
- 3) Tolerable signal distortion

peak random noise.

#### MODULATION RATE

Section 3 of RS-422 and RS-423 states that the unbalanced voltage interface will normally be utilized on data, timing or control circuits where the modulation rate on these circuits is below 100 kilobauds, and balanced voltage digital interface on circuits up to 10 megabauds. The voltage digital interface devices meeting the electrical characteristics of this standard need not meet the entire modulation range specified. They may be designed to operate over narrower ranges to more economically satisfy specific applications, particularly at the lower modulation rates.

As pointed out in AN-108, the duty cycle of the transmitted signal contributes to the distortion. The effect is the result of rise time. Due to delay and attenuation caused by the cable, it is possible due to AC averaging of the signal, to be unable to reach one binary level before it is changed to another. If the duty cycle is 1/2 (50%) and the receiver threshold is midway between logic levels, the distortion is small. However if the duty cycle were 1/8 (12.5%) the signal would be considerably distorted.

#### CHARACTERISTICS

#### Driver Unbalanced (RS-423)

The unbalanced driver characteristics as specified by RS-423 Sec 4.1 are as follows:

- A driver circuit should be a low impedance (50 Ohms or less) unbalanced voltage source that will produce a voltage applied to the interconnecting cable in the range of 4 volts to 6 volts.
- 2) With a test load of 450 Ohms connected between the driver output terminal and the driver circuit ground, the magnitude of the voltage (VT) measured between the driver output and the driver circuit ground shall not be less than 90% of the magnitude for either binary state.
- 3) During transitions of the driver output between alternating binary states, the signal measured across a 450 Ohm test load connected between the driver output and circuit ground should be such that the voltage monotonically changes between 0.1 and 0.9 of Vss. Thereafter, the signal shall not vary more than 10% of Vss from the steady state value, until the next binary transition occurs, and at no time shall the instantaneous magnitude of VT and VT exceed 6 volts, nor be less than 4 volts. Vss is defined as the voltage difference between the 2 steady state values of the driver output.

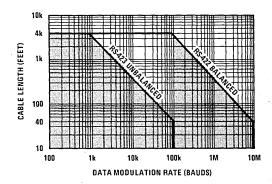
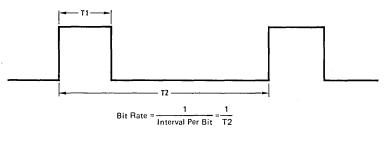


FIGURE 2. Data Modulation Rate vs Cable Length



Baud Rate = 
$$\frac{1}{\text{Minimum Unit Interval}} = \frac{1}{\text{T1}}$$

FIGURE 3a. Definition of Baud Rate

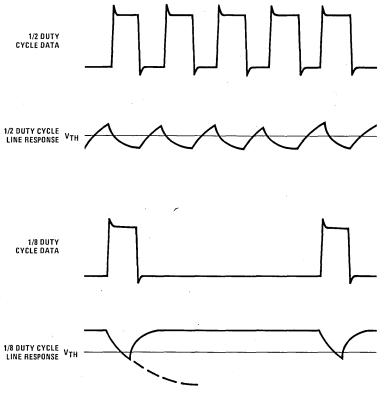


FIGURE 3b. Signal Distortion Due to Duty Cycle

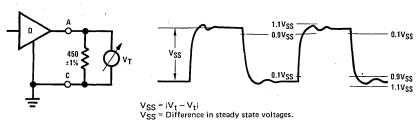


FIGURE 4. Unbalanced Driver Output Signal Waveform

#### Driver Balanced (RS-422)

The balanced driver characteristics as specified by RS-422 Sec 4.1 are as follows:

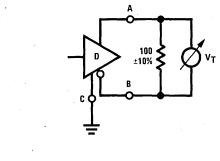
- A driver circuit should result in a low impedance (100 Ohms or less) balanced voltage source that will produce a differential voltage applied to the interconnecting cable in the range of 2 volts to 6 volts.
- 2) With a test load of 2 resistors, 50 Ohms each, connected in series between the driver output terminals, the magnitude of the differential voltage (VT) measured between the 2 output terminals shall not be less than either 2.0 volts or 50% of the magnitude of VO, whichever is greater. For the opposite binary state the polarity of VT shall be reversed (VT). The magnitude of the difference in the magnitude of VT and VT shall be less than 0.4 volts. The magnitude of the driver offset voltage (VOS) measured between the center point of the test load and driver circuit ground shall not be greater than 3.0 volts. The magnitude of the difference in the magnitude of Vos for one binary state and Vos for the opposing binary state shall be less than 0.4 volts.
- 3) During transitions of the driver output between alternating binary states, the differential signal measured across a 100 Ohm test load connected between the driver output terminals shall be

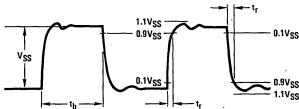
such that the voltage monotonically changes between 0.1 and 0.9 of VSS within 0.1 of the unit interval or 20 nanoseconds, whichever is greater. Thereafter the signal voltage shall not vary more than 10% of VSS from the steady state value, until the next binary transition occurs, and at no time shall the instantaneous magnitude of VT or  $\overline{\text{VT}}$  exceed 6 volts, nor less than 2 volts.

#### Interconnecting Cable

The characteristics of the interconnecting cable should result in a transmission line with a characteristic impedance in the general range of 100 Ohms to frequencies greater than 100 kilohertz, and a DC series loop resistance not exceeding 240 Ohms. The cable may be composed of twisted or untwisted pair (flat cable) possessing the characteristics specified in RS-422 Sec 4.3 as follows:

- Conductor size of the 2 wires shall be 24 AWG or larger with wire resistance not to exceed 30 Ohms per 1000 feet per conductor
- Mutual pair capacitance between 1 wire in the pair to the other shall not exceed 20 pF per foot.
- Stray capacitance between 1 wire in the pair with all other wires connected to ground, shall not exceed 40 pF per foot.





th = Time duration of the unit interval at the applicable modulation rate.

 $t_r\!\leq\!0.1~t_b$  when  $t_b\!\geq\!200~ns$ 

 $t_r \le 20$  ns when  $t_b < 200$  ns

V<sub>SS</sub> = Difference in steady state voltages

 $V_{SS} = |V_t - V_t|$ 

FIGURE 5. Balanced Driver Output Signal Waveform

The load characteristics are identical for both balanced (RS-422) and unbalanced (RS-423) circuits. Each consists of a receiver and optional termination resistance as shown in *Figure 1*. The electrical characteristics single receiver without termination or optional failsafe provisions are specified in RS-422/423 Sec 4.2 as follows:

- 1) Over an entire common-mode voltage range of -7 to +7 volts, the receiver shall not require a differential input voltage or more than 200 millivolts to correctly assume the intended binary state. The common-mode voltage (V<sub>CM</sub>) is defined as the algebraic mean of the 2 voltages appearing at the receiver input terminals with respect to the receiver circuit ground. Reversing the polarity of VT shall cause the receiver to assume the opposite binary state. This allows for operations where there are ground differences caused by IR drop and noise of up to ±7 volts.
- To maintain correct operation for differential input signal voltages ranging between 200 millivolts and 6 volts in magnitude.
- 3) The maximum voltage present between either receiver input terminal and receiver circuit ground shall not exceed 10 volts (3 volt signal plus 7 volts common-mode) in magnitude nor cause the receiver to operationally fail. Additionally, the receiver shall tolerate a maximum differential signal of 12 volts applied across its input terminals without being damaged.
- 4) The total load including up to 10 receivers shall not have a resistance greater than 90 Ohms for balanced, and 400 Ohms unbalanced at its input points and shall not require a differential input voltage of greater than 200 millivolts for all receivers to assume the correct binary state.

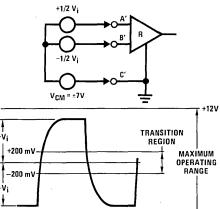


FIGURE 6. Receiver Input Sensitivity Measurement

Note: Designers of terminating hardware should be aware that slow signal transitions with superimposed noise present may give rise to instability or oscillations in the receiving device, and therefore appropriate techniques should be implemented to prevent such behavior. For example, adequate hysteresis and response control may be incorporated into the receiver to prevent such conditions.

5) Fail-safe operation per RS-423 Sec 4.2.5 states that other standards and specifications using the electrical characteristics of the unbalanced interface circuit may require that specific interchange leads be made fail-safe to certain fault conditions. Where fail-safe operation is required by such referencing standards and specifications, a provision shall be incorporated in the load to provide a steady binary condition (either "1" or "0") to protect against certain fault conditions (open or shorted cable).

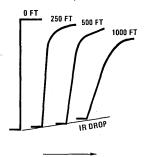
The designer should be aware that in circuits employing pull-up resistors, the resistors used become part of the termination.

#### SIGNAL RISE TIME

The signal rise time is a high frequency component which causes interference (near end cross-talk) to be coupled to adjacent channels in the interconnecting cable. The near-end crosstalk is a function of both rise time and cable length, and in considering wave shaping, both should be considered. Since in the balanced voltage digital interface the output is complementary, there is practically no cross-talk coupled and therefore wave shaping is limited to unbalanced circuits.

Per RS-423 Sec 4.1.6, the rise time of the signal should be controlled so that the signal has reached 90% of VSS between 10% and 30% of the unit interval at the maximum modulation rate. Below 1 kilobaud the time to reach 90% VSS shall be between 100 and 300 microseconds. If a driver is to operate over a range of modulation rates and employ a fixed amount of wave shaping which meets the specification for the maximum modulation rate of the operating range, the wave shaping is considered adequate for all lesser modulation rates.

However a major cause of distortion is the effect the transmission line has on the rise time of the transmitted signal. Figure 7 shows the effect of line attenuation and delay to a voltage step as it progresses down the cable. The increase of the rise time with distance will have a considerable effect on the distortion at the receiver. Therefore in fixing the amount of wave shaping employed, caution should be taken not to use more than the minimum required.



TIME
FIGURE 7. Signal Rise Time on Transmission Line vs
Line Length

#### DS1691, DS78LS120 The Driver

The DS1691/DS3691 are low power Schottky TTL line drivers designed to meet the above listed requirements of EIA standard RS-422 and RS-423. They feature 4 buffered outputs with high source and sink current capability with internal short circuit protection. The DS1691/DS3691 employ a mode selection pin which allows the circuit to become either a pair of balanced drivers (Figure 8) or 4 independent unbalanced drivers (Figure 10) a rise time control pin allows the use of an external capacitor to control rise time for suppression of near end cross-talk to adjacent channels in the interconnect cable. Figure 11 is the typical rise time vs external capacitor used for wave shaping.

The DS3691 configured for RS-422 is connected  $V_{CC}$  = 5V VEE = 0V, and configured for RS-423 connected  $V_{CC}$  = 5V VEE = -5V. For applications outside RS-422 conditions and for greater cable lengths the DS1691/DS3691 may be connected with a  $V_{CC}$  of 5 volts and  $V_{EE}$  of -5 volts. This will create an output which is symmetrical about ground, similar to Mil Standard 188-114.

When configured as balanced drivers (Figure 8), each of the drivers is equipped with an independent TRI-STATE® control pin. By use of this pin it is possible to force the driver into its high impedance mode for applications using party line techniques.

If the common-mode voltage, between driver 1 and all other drivers in the circuit, is small then several line drivers (and receivers) may be incorporated into the system. However, if the common-mode voltage exceeds the TRI-STATE common-mode range of any driver, then the signal will become attenuated by that driver to the extent the common-mode voltage exceeds its common-mode range (See Figure 12, top waveform).

It is important then to select a driver with a common-mode range equal to or larger than the common-mode voltage requirement of the system. In the case of RS-422 and RS-423 the minimum common-mode range would be  $\pm 7$  volts. The DS1692/DS3692 driver is tested to a common-mode range of  $\pm 10$  volts and will operate within the requirements of such a system (See *Figure 12*, bottom waveform).

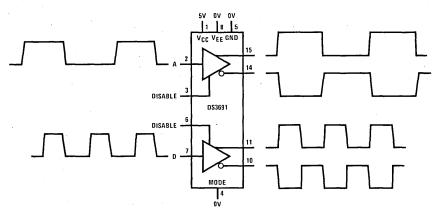


FIGURE 8. DS3691 Connected for Balanced Mode Operation

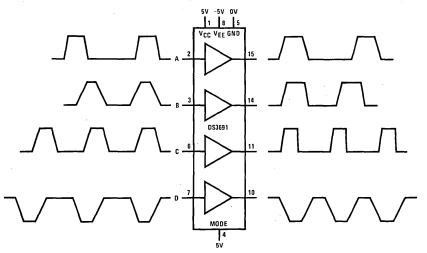
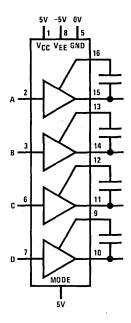


FIGURE 9. DS3691 Connected for Unbalanced Mode Operation



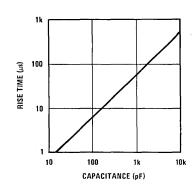


FIGURE 10. Using an External Capacitor to Control Rise Time of DS3691

FIGURE 11. DS3691 Rise Time vs External Capacitor

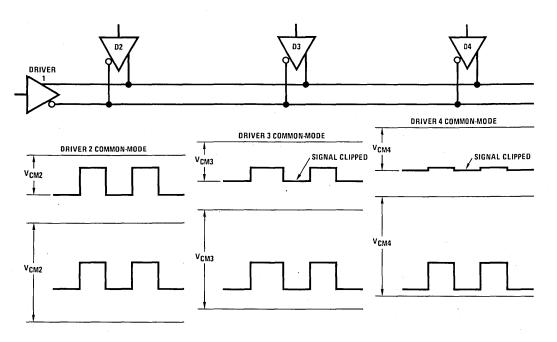


FIGURE 12. Comparison of Drivers without TRI-STATE Common-mode Output Range (Top Waveforms) to DS3691 (Bottom Waveforms)

#### DS78LS120/DS88LS120 The Receiver

The DS78LS120/DS88LS120 are high performance, dual differential, TTL compatible line receivers which meet or exceed the above listed requirements for both balanced and unbalanced voltage digital interface.

The line receiver will discriminate a  $\pm 200$  millivolt input signal over a full common-mode range of  $\pm 10$  volts and a  $\pm 300$  millivolt signal over a full common-mode range of  $\pm 15$  volts.

The DS78LS120/DS88LS120 include response control for applications where controlled rise and fall times and/or high frequency noise rejection are desirable. Switching noise which may occur on the input signal

can be eliminated by the 50 mV (referred to input) of hysterisis built into the output gate (Figure 14). The DS78LS120/DS88LS120 makes use of a response control pin for the addition of an external capacitor, which will not effect the line termination impedance of the interconnect cable. Noise pulse width rejection versus the value of the response control capacitor is shown in Figure 15. The combination of the filter followed by hysteresis will optimize performance in a worse case noise environment. The DS78C120/DS88C120 is identical in performance to the DS78LS120/DS88LS120, except it's compatible with CMOS logic gates.

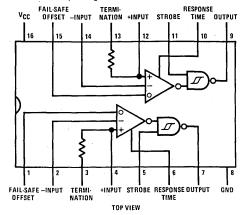


FIGURE 13. DS78LS120/DS88LS120 Dual Differential Line Receiver

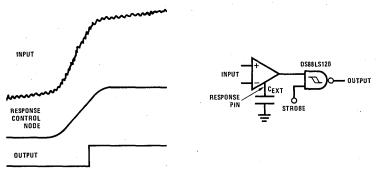
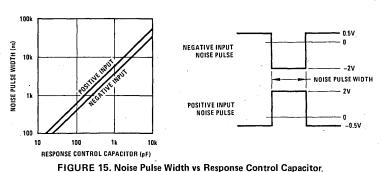


FIGURE 14. Application of DS88LS120 Receiver Response Control and Hysteresis



Communication systems require elements of a system to detect the loss of signals in the transmission lines. And it is desirable to have the system shut-down in a fail-safe mode if the transmission line is open or short. To facilitate the detection of input opens or shorts, the DS78LS120/DS88LS120 incorporates an input threshold voltage offset. This feature will force the line receiver to a specific logic state if presence of either fault condition exists.

The receiver input threshold is  $\pm 200$  millivolts and an input signal greater than  $\pm 200$  millivolts insures the receiver will be in a specific logic state. When the offset control input is connected to a V<sub>CC</sub> = 5 volts, the input thresholds are offset from 200 to 700 millivolts, referred to the non-inverting input, or -200 to -700 millivolts, referred to the inverting input. Therefore, if the input is open or short, the input will remain in a specific state (See *Figure 16*).

It is recommended that the receiver be terminated in 500 Ohms or less to insure it will detect an open circuit in the presence of noise.

For unbalanced operation, the receiver would be in an indeterminate logic state if the offset control input was open. Connecting the offset to +5 volts, offsets the receiver threshold 0.45 volts. The output is forced to a logic zero state if the input is open or short.

For balanced operation with inputs short or open, receiver C will be in an indeterminate logic state. Receivers A and B will be in a logic zero state allowing the NOR gate to detect the short or open fault condition. The "strobe" input will disable the A and B receivers and therefore may be used to "sample" the fail-safe detector (See Figure 17).

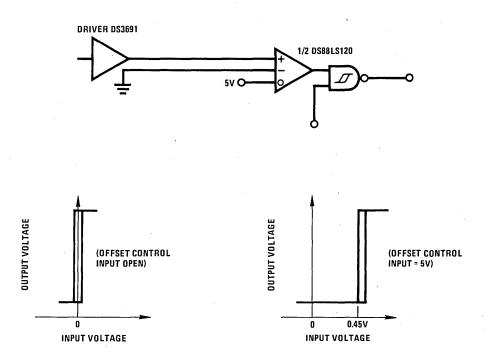
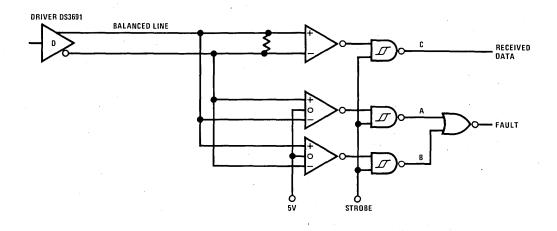


FIGURE 16. Fail-Safe Using the DS88LS120 Threshold Offset for Unbalanced Lines



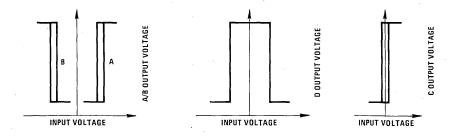


FIGURE 17. Fail-Safe Using the DS88LS120 Threshold Offset for Balanced Lines

# Summary of Electrical Characteristics of Some Well Known Digital Interface Standards

National Semiconductor Application Note 216 Don Tarver December 1978



#### **FORWARD**

Not the least of the problems associated with the design or use of data processing equipment is the problem of providing for or, actually, interconnecting the differing types and models of equipment to form specific processing systems.

The magnitude of the problem becomes apparent when one realizes that every aspect of the electrical, mechanical and architectural format must be specified. The most common of the basic decisions confronting the engineer include:

- Type of logic (negative or positive)
- Threshold levels
- Noise immunity
- Form of transmission
  - Balanced/unbalanced, terminated/unterminated
  - Unidirectional/bidirectional, simplex/multiplexed
- Type of transmission line
- Connector type and pin out
- Bit or byte oriented
- Baud rate

If each make and/or model of equipment presented a unique interface at its I/O ports, "interface" engineering would become a major expenditure associated with the use of data processing equipment.

Fortunately, this is not the case as various interested or cognizant groups have analyzed specific recurring interface areas and recommended "official" standards around which common I/O ports could be structured. Also, the I/O specifications of some equipment with widespread popularity such as the IBM 360/370 computer and DEC minicomputer have become "defacto"

standards because of the desire to provide/use equipment which interconnect to them.

Compliance with either the "official" or "defacto" standards on the part of equipment manufacturers is voluntary. However, it is obvious that much can be gained and little lost by providing equipment that offers either the "official" or "defacto" standard I/O ports.

As can be imagined, the entire subject of interface in data processing systems is complicated and confusing, particularly to those not intimately involved in the day-to-day aspects of interface engineering or management. However, at the component level the questions simplify to knowing what standards apply and what circuits or components are available to meet the standards.

This application note summarizes the important electrical characteristics of the most commonly accepted interface standards and offers recommendations on how to use National Semiconductor integrated circuits to meet those standards.

#### 1.0 INTRODUCTION

The interface standards covered in this application note are listed in Table I. The body of the text expands upon the scope and application of each listed standard and summarizes important electrical parameters.

Table 11 summarizes the National Semiconductor IC's applicable to each standard.

TABLE I. COMMON LINE DRIVER/RECEIVER INTERFACE STANDARDS SUMMARY

INTERFACE AREA	APPLICATION	STANDARD	ORIGIN	COMMENTS
Data Communications Equip-	U.S.A. Industrial	RS232C	EIA .	Unbalanced, Short Lines
ment (DCE*) to Data Terminal		RS422	EIA	Balanced, Long Lines
Equipment (DTE)	,	RS423	EIA	Unbalanced, RS232 Up-
•	,			Grade
!		RS449	EIA	System Standard Coverin
	, , , , , , , , , , , , , , , , , , ,			Use of RS422, RS423
	International	CCITT Vol. VIII	International	Similar to RS232
		V. 24	Telephone	
		CCITT No. 97	and Telegraph	Similar to RS423
		X. 26	Consultative	
		CCITT No. 97	Committee	Similar to RS422
		X. 27		•
•	U.S.A. Military	MIL-STD-188C	D.O.D.	Unbalanced, Short Lines
		MIL-STD-188-114	D.O.D.	Similar to RS422, RS423
		MIL-STD-1397	Navý	42k bits/sec
		(NTDS-Slow)		
		MIL-STD-1397	Navy	250k bits/sec
	`	(NTDS-Fast)		
	U.S. Government,	FED-STD-1020	GSA	Identical to RS423
	Non-Military	FED-STD-1030	GSA	Identical to RS422
Computer to	IBM 360/370	System 360/370	IBM	Unbalanced Bus
Peripheral	;	Channel I/O		Chibalanda Bas
·	DEC	DEC	DE0	Habatan and Don
	Mini-Computer	Unibus®	DEC	Unbalanced Bus
Instrument to	Nuclear Instru-	CAMAC	NIM	DTL/TTL
Computer	mentation	(IEEE std. 583-1975)	(AEC)	Logic Levels
	Laboratory Instru-	488	IEEE	Unbalanced Bus
	mentation			
Microprocessor to	Microprocessor	Microbus <sup>TM</sup>	National	Short Line; 8-Bit Parallel,
Interface Devices	Circuits		Semiconductor	Digital Transmission
Facsimile Equipment	Facsimile	RS357	EIA	Incorporates RS232
to DTE	Transmission	,		
Automatic Calling Equip-	Impulse Dialing	RS366	EIA	Incorporates RS232
ment to DTE	and Multi-Tone			moorpolates Nozoz
	Keying	•		
Alaman da Har Oaraha Hari		B0400	FIA	Charalter / CA 5: \
Numerically Controlled	Numerically Controlled	RS408	EIA	Short Lines (<4 Ft.)
Equipment to DTE	Equipment			·

<sup>\*</sup>Changed to "Data Circuit—Terminating Equipment" <sup>®</sup>Registered trademark of Digital Equipment Corp.

## TABLE II. LINE DRIVER/RECEIVER INTEGRATED CIRCUIT SELECTION GUIDE FOR DIGITAL INTERFACE STANDARDS

STANDARD			PART NUMBER				
DESIGNATION		DRIVER		RECEIVER			
	0°C TO +70°C	−55°C TO +125°C	0°C TO +70°C	-55°C TO +125°			
U.S. Industrial Standa	ırds	-		1			
RS232C	DS1488	Not Applicable	DS1489 (A)	Not Applicable			
	DS75150	Not Applicable	DS75154	Not Applicable			
RS357	See RS232C						
RS366	See RS232C						
RS408	DS75453	DS55454	DS7820A	DS7820A			
	DS75454	DS55454	DS75115	DS55115			
RS422	DS3691	DS1691A	DS88LS120	DS78LS120			
	DS26LS31C	DS26LS31M	DS26LS32C	DS26LS32M			
	DS3487	DS3587	DS3486				
		*	DS26LS33C	DS26LS33M			
			DS88C20	DS78C20			
	·		DS88C120	DS78C120			
RS423	DS3691	DS1691A	DS88LS120	DS78LS120			
	DS3692	DS1692	DS88C20	DS78C20			
•		•	DS88C120	DS78C120			
RS449`.	See RS422, RS423						
IEEE 488	DS3666		DS3666				
	DS75160A		DS75160A				
	DS75161A		DS75161A				
	DS75162A		DS75162A				
CAMAC	See RS232C, RS422	, RS423 or IEEE 488					
IBM 360/370	DS75123	Not Applicable	DS75124	Not Applicable			
I/O Port							
DEC Unibus®	DS36147	DS16147	DS8640	DS7640			
	D\$8641	DS7641	DS8641	DS7641			
	Transceiver	Transceiver	Transceiver	Transceiver			
Microbus <sup>TM</sup>	DS3628	DS1628					
	DP8228	DP8228M					
	DP8216	DP8216M		,			
	DP8212	DP8212M					
	DP8304B		DP8304B				
	Transceiver		Transceiver				
Government Standard	s		····				
MIL-STD-188C	D\$3692	DS1692	DS88LS120	DS78LS120			
MIL-STD-188-114	DS3692	DS1692	DS88LS120	DS78LS120			
FED-STD-1020	See RS423		. 1				
FED-STD-1030	See RS422		<u> </u>				
MIL-STD-1397 (NTDS-Slow)	Use Discrete Compo	nents and/or Comparators					
MIL-STD-1397 (NTDS—Fast)	Use Discrete Compo	nents and/or Comparators					

## TABLE II. LINE DRIVER/RECEIVER INTEGRATED CIRCUIT SELECTION GUIDE FOR DIGITAL INTERFACE STANDARDS (Continued)

CTANDADD		PART NUMBER						
STANDARD DESIGNATION	LINE	DRIVER	LINE	RECEIVER				
DESIGNATION	0°C TO +70°C	−55°C TO +125°C	0°C TO +70°C	-55°C TO +125°C				
International Standard	is (CCITT)							
1969 White Book Vol. VIII, V. 24	See RS232C							
Circular No. 97, X. 26	See RS422							
Circular No. 97, '	See RS423							

## 2.0 DATA TERMINAL EQUIPMENT (DTE) TO DATA COMMUNICATIONS EQUIPMENT (DCE) INTERFACE STANDARDS

#### 2.1 Application

The DTE/DCE standards cover the electrical, mechanical and functional interface between/among terminals (i.e., teletypewriters, CRTs, etc.) and communications equipment (i.e., modems, cryptographic sets, etc.).

#### 2.2 U.S. Industrial DTE/DCE Standards

#### 2.2.1 EIA RS232C

The oldest and most widely known DTE/DCE standard. It provides for one-way/non-reversible, single-ended (unbalanced), non-terminated line, serial digital data transmission.

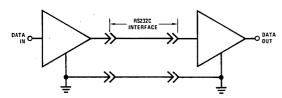


FIGURE 1, EIA RS232C Application

Important features are:

- a) Positive logic (±5V min to ±15V max)
- b) Fault protection
- c) Slew-rate control
- d) 50 feet recommended cable length and 20k bits per second data signaling rate.

#### 2.2.2 EIA RS422, RS423

In a move to upgrade system capabilities by utilizing state-of-the-art devices and

technology the EIA, in 1975, introduced 2 new specifications covering:

- Single-ended data transmission at modulation rates up to kilobaud\* (RS423)
- 2) Balanced data transmission at modulation rates up to 10 megabaud (RS422).

#### 2.2.2.1 RS423

RS423 closely resembles RS232C in that it, too, specifies one-way/non-reversible, single-ended, data transmission lines. Key differences between RS423 and RS232C are:

#### RS423

4V to 6V Logical "1"

-4V to -6V Logical "0"

100k Baud at 40 Feet

Balanced Receiver, Referred
to Driver Ground, Permitting
Ground Potential Difference
Between Driver and Receiver

#### RS232

5V to 15V Logical "1" -5V to -25V Logical "0" 20k Baud at 50 Feet Unbalanced Receiver

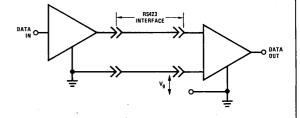


FIGURE 2. EIA R\$423 Application

<sup>\*</sup> Modulation rate = reciprocal of minimum pulsewidth (i.e., 20 ms pulse = 50 baud)

TABLE III. EIA RS232C SPECIFICATION SUMMARY

	DADAMETED	CONDITIONS		EIA RS2320	2	LINUTC
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
VOH VOL	Driver Output Voltage Open Circuit		-25		25	V.
VOH VOL	Driver Output Voltage Loaded Output	$3 \text{ k}\Omega \leq \text{R}  \text{L} \leq 7 \text{ k}\Omega$	5 -15		15 5	v v
RO	Driver Output Resistance Power OFF	$-2V \le V_0 \le 2V$			300	Ω
los	Driver Output Short-Circuit Current		-500		500	mA
·	Driver Output Slew Rate All Interchange Circuits Control Circuits Rate and Timing Circuits	% of Unit Interval	6 6 4		30	V/μs V/ms V/ms
R <sub>IN</sub>	Receiver Input Resistance Receiver Open Circuit Input Bias Voltage	$3V \le V_{IN} \le 25V$	3000 2	,	7000 2	Ω V
	Receiver Input Threshold Output = MARK Output = SPACE		-3		3	V V

#### TABLE IV. EIA RS423 SPECIFICATION SUMMARY

	DADAMETED	CONDITIONS		EIA RS423		UNITS
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
	Driver Unloaded Output Voltage		4		6	
$\overline{v_0}$			-4		-6	V
$V_{T}$	Driver Loaded Output Voltage	$R_L = 450\Omega$	3.6			V
$\overline{V_T}$		•	-3.6			V
RS	Driver Output Resistance				50	Ω
IOS	Driver Output Short-Circuit	VO = 0V			±150	mA
	Current					
	Driver Output Rise and Fall	Baud Rate ≤ 1k Baud			300	μs
	Time	Baud Rate≥ 1k Baud			30	% Unit
			1			Interval
lox	Driver Power OFF Current	$V_0 = \pm 6V$			±100	μΑ
$v_{TH}$	Receiver Sensitivity	$V_{CM} \le \pm 7V$			±200	m∨
VCM	Receiver Common-Mode Range				±10	V
RIN	Receiver Input Resistance		4000		,	Ω
	Receiver Common-Mode Input				±3	v
	Offset			L		

#### 2.2.2.2 RS422

RS422 provides for balanced data transmission with unidirectional/non-reversible, terminated or non-terminated transmission lines. Important features are:

- a) ±2V to ±6V driver output
- b) 0.4V differential output matching
- c) ±200 mV receiver input sensitivity
- d) 10M baud modulation rate

#### 2.3 International Standards

2.3.1 CCITT 1969 White Book Vol. VIII, V. 24. This standard is identical to RS232C.

- 2.3.2 CCITT circular No. 97 Com SPA/13, X. 26. This standard is similar to RS422 with the exception that the receiver sensitivity at the specified maximum common-mode voltage (±7V) shall be ±300 mV vs ±200 mV for RS422.
- 2.3.3 CCITT circular No. 97 Com SPA/13, X. 27. This standard is similar to RS423 with 2 exceptions:
  - a) The receiver sensitivity is as specified in paragraph X. 26, and
  - b) The driver output voltage is specified at a load resistance of 3.9  $k\Omega$ .

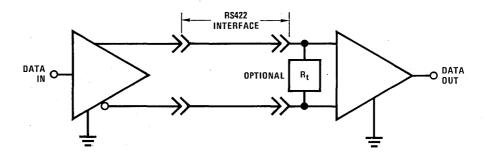


FIGURE 3. EIA RS422 Application

**TABLE V. EIA RS422 SPECIFICATION SUMMARY** 

	DADAMETED	CONDITIONS		EIA RS422		UNITS
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
$\frac{v_0}{v_0}$	Driver Unloaded Output Voltage				6 -6	V
$\frac{v_T}{v_T}$	Driver Loaded Output Voltage	R <sub>T</sub> = 100Ω	2 -2			V V
RS	Driver Output Resistance	Per Output	1		50	Ω
los	Driver Output Short-Circuit Current	V <sub>O</sub> = 0V	,		150	mA
	Driver Output Rise Time				10	% Unit
lox	Driver Power OFF Current	$-0.25V \le V_{O} \le 6V$			±100	μΑ
$V_{TH}$	Receiver Sensitivity	V <sub>CM</sub> = ±7V			200	m∨
V <sub>CM</sub>	Receiver Common-Mode Voltage		12		12	V
	Receiver Input Offset		±3			V

#### 2.4 U.S. Military Standards

#### 2.4.1 MIL-STD-188C (Low Level)

The military equivalent to RS232C is MIL-STD-188C. Devices intended for

RS232C can be applied to MIL-STD-188C by use of external wave shaping components on the driver end and input resistance and threshold tailoring on the receiver end.

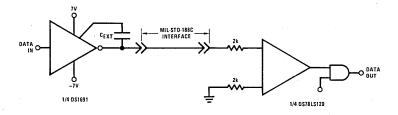


FIGURE 4. MIL-STD-188C Application

TABLE VI. MIL-STD-188C SPECIFICATION SUMMARY

	PARAMETER CONDITIONS		MIL-STD-188C LOW LEVEL LIMITS			UNITS	
			MIN	TYP	MAX	1	
Voн	Driver Output Voltage Open Circuit	(Note 1)	5		7	V	
$v_{OL}$			-7		-5	V	
$R_{O}$	Driver Output Resistance Power ON	I <sub>OUT</sub> ≤ 10 mA			100	Ω	
ios	Driver Output Short-Circuit Current		-100		100	· mA	
	Driver Output Slew Rate						
	All Interchange Circuits	(Note 2)	5		15	% IU	
	Control Circuits						
	Rate and Timing Circuits						
RIN	Receiver Input Resistance	Mod Rate ≤ 200k Baud	6	,		Ω	
	Receiver Input Threshold						
	Output = MARK	(Note 3)			100	μΑ	
	Output = SPACE		-100			μΑ	

Note 1: Ripple < 0.5%, VOH, VOL matched to within 10% of each other.

Note 2: Waveshaping required on driver output such that the signal rise or fall time is 5% to 15% of the unit interval at the applicable modulation rate.

Note 3: Balance between marking and spacing (threshold) currents actually required shall be within 10% of each other.

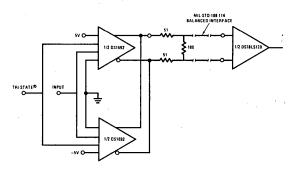


FIGURE 5. MIL-STD-188-114 (Balanced Applications)

#### 2.4.2 MIL-STD-188-114 Balanced

This standard is similar to RS422 with the exception that the driver offset voltage level is limited to  $\pm 0.4$ V vs  $\pm 3$ V allowed in RS422.

#### 2.4.3 MIL-STD-188-114 Unbalanced.

This standard is similar to RS423 with the exception that loaded circuit driver output voltage at  $R_L=450\Omega$  must be 90% of the open circuit output voltage vs  $\pm 2V$  at  $R_S=100\Omega$  for RS422.

#### 2.4.4 MIL-STD-1397 (Slow and Fast)

2.5 U.S. Government (non-military) standards FED-STD-1020 and 1030 are identical without exception to EIA RS423 and RS422, respectively.

## 3.0 COMPUTER TO PERIPHERAL INTERFACE STANDARDS

To date, the only standards dealing with the interface between processors and other equipment are the "defacto" standards in the form of specifications issued by IBM and DEC covering the models 360/370 I/O ports and the Unibus®, respectively.

3.1 IBM specification GA-22-6974-0 covers the electrical characteristics, the format of information and the control sequences of the data transmitted between 360/370's and up to 10 I/O ports.

The interface is an unbalanced bus using  $95\Omega$ , terminated, coax cables. Devices connected to the bus should feature short-circuit protection, hysteresis in the receivers, and open-emitter drivers. Careful attention should be paid to line lengths and quality in order to limit cable noise to less than 400 mV.

TABLE VII. MIL-STD-1397 SPECIFICATION SUMMARY

	PARAMETER CONDITIONS -			COMPARISON LIMITS (MIL-STD)		
	PARAMETER	CONDITIONS	1397 (SLOW)	1397 (FAST)	UNITS	
	Data Transmission Rate		42	250	k Bits/Sec	
$v_{OH}$	Driver Output Voltage		±1.5	0	V	
VOL			-10 to -15.5	-3	V	
ЮН	Driver Output Current		≥-4		mA	
lOL	i		1 1		mA	
$R_S$	Driver Power OFF Impedance		≥100		kΩ	
$v_{IH}$	Receiver Input Voltage	Fail-Safe Open Circuit	≤4.5	≤−1.1	V	
VIL			≥-7.5	≥-1.9	V	

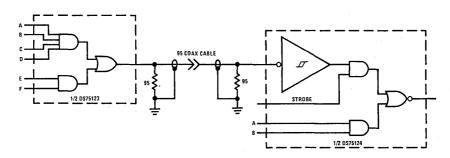


FIGURE 6. IBM 360/370 I/O Application

<sup>®</sup>Registered trademark of Digital Equipment Corp.

TABLE VIII. IBM 360/370 SPECIFICATION SUMMARY

	PARAMETER	CONDITIONS	I	BM 360/37	)	UNITS
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
۷он	Driver Output Voltage	I <sub>OH</sub> = 123 mA			7	V
۷он		$I_{OH} = 30 \mu A$			5.85	V
Voн		I <sub>OH</sub> = 59.3 mA	3.11			V
VOL		$I_{OL} = -240 \mu A$			0.15	V
$v_{IH}$	Receiver Input Threshold		İ		1.7	٧
VIL	Voltage		0.7			V
IIH -	Receiver Input Current	V <sub>IN</sub> = 3.11V			-0.42	mA
IIL		V <sub>IN</sub> = 0.15V	0.24		,	mA
	Receiver Input Voltage					
	Range			ľ	1	
$v_{IN}$	Power ON		-0.15		7	V
$v_{IN}$	Power OFF		-0.15		6	V
RIN	Receiver Input Impedance	$0.15V \leq V_{\mbox{\footnotesize{IN}}} \leq 3.9V$	7400			Ω
IIN	Receiver Input Current	V <sub>IN</sub> = 0.15V			240	μΑ
zo	CABLE Impedance		83		101	Ω
Ro	CABLE Termination	$P_D \ge 390 \text{ mW}$	90		100	Ω
	Line Length (Specified as				400	, mV
	Noise on Signal and Ground Lines)					

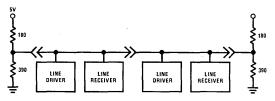


FIGURE 7. DEC Unibus® Application

### TABLE IX. DEC UNIBUS ® SPECIFICATION SUMMARY

PARAMETER		PARAMETER CONDITIONS		DEC UNIBUS®			
		CONDITIONS	MIN	TYP	MAX	UNITS	
VOL	Driver Output Voltage	I <sub>OL</sub> = 50 mA			0.7	V	
Vo		Absolute Maximum			7	V	
VIH	Receiver Input Voltage		1.7			V	
VIL					1.3	V	
ЧН (	Receiver Input Current	V <sub>IN</sub> = 4V			100	μΑ	
HL		V <sub>IN</sub> = 4V Power OFF			100	$\mu A$	

#### 3.2 DEC Unibus®

Another example of an unofficial industry standard is the interface to a number of DEC minicomputers. This interface, configured as a  $120\Omega$  double-terminated data bus is given the

name Unibus<sup>®</sup>. Devices connected to the bus should feature hysteresis in the receivers and open-collector driver outputs. Cable noise should be held to less than 600 mV.

<sup>®</sup>Registered trademark of Digital Equipment Corp.

#### 4.0 INSTRUMENTATION TO COMPUTER INTER-FACE STANDARDS

#### 4.1 Introduction

The problem of linking instrumentation to processors to handle real-time test and measurement problems was largely a custom interface problem. Each combination of instruments demanded unique interfaces, thus inhibiting the wide spread usage of small processors to day-to-day test, measurement and control applications.

Two groups addressed the problem for specific environments. The results are:

 IEEE 488 bus standard based upon proposals made by HP, and  The CAMAC system pioneered by the nuclear physics community.

#### 4.2 IEEE 488

IEEE 488 covers the functional, mechanical and electrical interface between laboratory instrumentation (i.e., signal generators, DPM's, counters, etc.) and processors such as programmable calculators and minicomputers. Equipment with IEEE 488 I/O ports can be readily daisy chained in any combination of up to 15 equipments (including processor) spanning distances of up to 60 feet. 16 lines (3 handshake, 5 control and 8 data lines) are required.

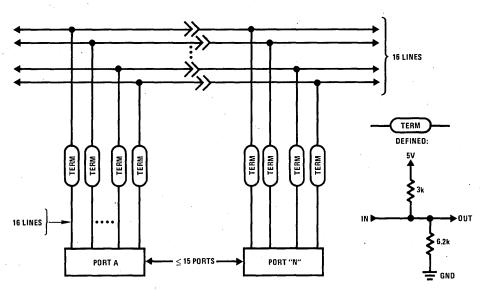


FIGURE 8, IEEE 488 Application

**TABLE X, IEEE 488 SPECIFICATION SUMMARY** 

	DADAMETED	CONDITIONS		<b>IEEE 488</b>		LINUTO
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
Уон	Driver Output Voltage	I <sub>OH</sub> = -5.2 mA	2.4			
$v_{OL}$		IOL = 48 mA			0.4	V
	Driver Output Current		j		ļ.	
loz	TRI-STATE®	V <sub>O</sub> = 2.4V			±40	μĄ
Іон	Open Collector	V <sub>O</sub> = 5.25V			250	μΑ
VIH	Receiver Input Voltage	0.4V Hysteresis Recommended	2.0			V
VIL					0.8	V
hн .	Receiver Input Current	V <sub>IN</sub> = 2.4V			40	μΑ
IIL	•	V <sub>IN</sub> = 0.4V			-1.6	mA
	Receiver Clamp Current	V <sub>IN</sub> = -1.5V			12	mA
R <sub>L1</sub>	Termination Resistor	V <sub>CC</sub> = 5V (±5%)	2850		3150	
R <sub>L2</sub>		V = Gnd	5890		6510	*

#### 4.3 CAMAC

The CAMAC system is the result of efforts by those in the nuclear physics community to standardize the interface between laboratory instruments and computers before the introduction of IEEE 488.

It allows either serial or parallel interconnection of instruments via a "crate" controller.

The electrical requirements of the interfaces are compatible with DTL and TTL logic levels.

## 5.0 MICROPROCESSOR SYSTEMS INTERFACE STANDARDS

5.1 Microprocessor systems are bus organized systems with two types of bus requirements:

- a) Minimal system: for data transfer over short distances (usually on 1 PC board), and,
- Expanded system: for data transfer to extend the memory or computational capabilities of the system.

#### 5.2 Minimal Systems and Microbus<sup>TM</sup>

Microbus<sup>TM</sup> considers the interface between MOS/LSI microprocessors and interfacing devices in close physical proximity which communicate over 8-bit parallel unified bus systems. It specifies both the functional and electrical characteristics of the interface and is modeled after the 8060, 8080 and 8900 families of microprocessors as shown in *Figures 8*, 9 and 10.

The electrical characteristics of Microbus are shown in Table XI.

TABLE XI. MICROBUS ELECTRICAL SPECIFICATION SUMMARY

			REC	CEIVER	
٠	PARAMETER	DRIVER	STANDARD	HYSTERESIS (RECOMMENDED)	UNITS
VOL	Output Voltage (At 1.6 mA)	≤0.4V			
Voн	$(At -100 \mu A)$	≥2.4V		,	
$v_{IL}$	Input Voltage		0.8	0.6	· v
V <sub>IH</sub>			2.0	2.0	V
	Internal Capacitive Load at 25°C	15	10	10	pF
t <sub>r</sub>	Rise Time (Maximum)	100			ns
tf	Fall Time (Maximum)	100			ns

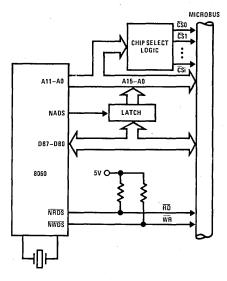


FIGURE 9. 8060 SC/MP II System Model

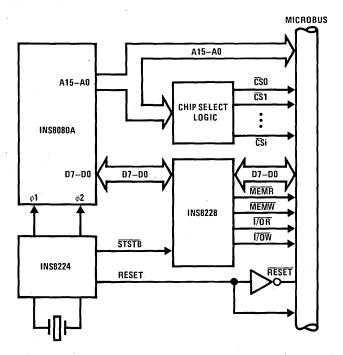


FIGURE 10. 8080 System Model for the Basic Microbus Interface

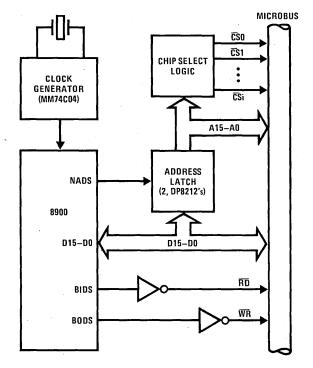


FIGURE 11, 8900 System Model

#### 5.3 Expanded Microprocessor System Interfaces

Since the outputs of most microprocessor devices are limited to a loading of one relative to a TTL load, expanded systems will require buffers on both their address and data lines.

To date, no formal standards exist which govern this interface. However, "defacto" standards are emerging in the form of the specifications for "recommended devices" which are mentioned in the data sheets and application notes for the widely sourced microprocessor devices. Here, the answer to the question of how to provide a "standard" interface is simplified to that of proper usage of recommended devices.

Table XII summarizes the important electrical characteristics of recommended bus drivers for expanded microprocessor systems.

#### 6.0 OTHER INTERFACE STANDARDS

Some other commonly occurring interfaces which have become standardized are:

 Interface between facsimile terminals and voice frequency communications terminals,

- Interface between terminals and automatic calling equipment used for data communications, and
- Interface between numerically controlled equipment and data terminals.

#### 6.1 EIA RS357

RS357 defines the electrical, functional and mechanical characteristics of the interface between analog facsimile equipment to be used for telephone data transmission and the data sets used for controlling/transmitting the data.

Figure 11 summarizes the functional and electrical characteristics of RS357.

#### 6.2 EIA RS366

RS366 defines the electrical, functional and mechanical characteristics of the interface between automatic calling equipment for data communications and data terminal equipment.

The electrical characteristics are encompassed by RS232C.

TABLE XII. RECOMMENDED SPECIFICATION OF BUS DRIVERS FOR EXPANDED MICROPROCESSOR SYSTEMS

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
VIH	Driver Input Voltage		2			V
VIL					0.8	V
Voн	Driver Output Voltage	IOH = -10 mA	2.4			V
$v_{OL}$		IOL = 48 mA		1	0.5	V 1
los	Short-Circuit Current	V <sub>CC</sub> = 5.25V			-150	mA
CL	Bus Drive Capability		300			pF

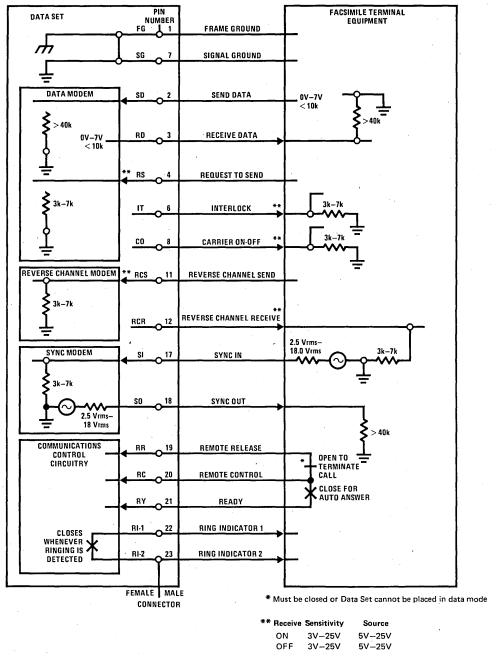


FIGURE 12. Functional and Electrical Characteristics of RS357

#### 6.3 EIA RS408

RS408 recommends the standardization of the 2 interfaces shown in *Figure 13*.

The electrical characteristics of NCE to DTE interface are, in summary, those of conventional TTL drivers (series 7400) with:

 $V_{OL} \leq 0.4V$  at  $I_{OL}$  = 48 mA  $V_{OH} \geq 2.4V \text{ at } I_{OH} \leq -1.2 \text{ mA, and}$   $C_L \leq 2000 \text{ pF.}$ 

Short circuit protection should be provided.

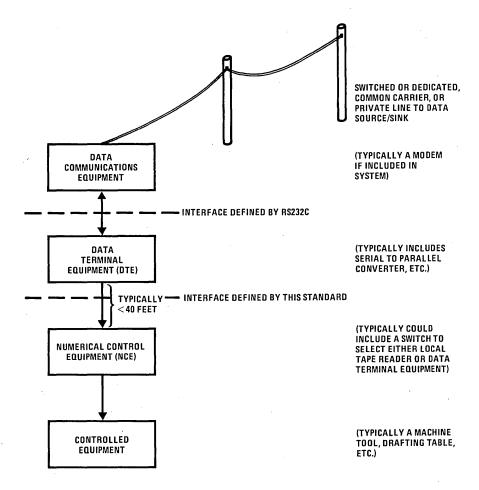


FIGURE 13. EIA RS408 Interface Applications



# Section 2 **Bus Transceivers**

TEMPERATUR - 55°C to + 125°C	RE RANGE 0°C to +70°C	DESCRIPTION	PAGE NUMBER
*DP7303	DP8303	8-Bit TRI-STATE Bidirectional Transceivers	2-5, 2-6
*DP7304B	DP8304B	8-Bit TRI-STATE Bidirectional Transceivers	2-5, 2-11
*DP7307	DP8307	8-Bit TRI-STATE Bidirectional Transceivers	2-5, 2-16
*DP7308	DP8308	8-Bit TRI-STATE Bidirectional Transceivers	2-5, 2-20
*DS26S10M	DS26S10	Quad Bus Transceiver	2-24
*DS26S11M	DS26S11	Quad Bus Transceiver	2-24
	DS3662	Quad High Speed Trapezoidal Bus Transceiver	2-29
	AN-259	DS3662—The Bus Optimizer	2-33
	AN-337	Reducing Noise on Microcomputer Buses	2-40
<del></del>	DS3666	IEEE-488 GPIB Transceiver	2-48
_	DS3667	TRI-STATE Bidirectional Transceiver	2-56
*******	DS75160A	IEEE-488 GPIB Transceiver	2-61
<del></del>	DS75161A	IEEE-488 GPIB Transceiver	2-61
_	DS75162A	IEEE-488 GPIB Transceiver	2-61
*DS7640	DS8640	Quad NOR Unified Bus Receiver	2-68
*DS7641	DS8641	Quad Unified Bus Transceiver	2-70
_	DS8642	Quad Transceiver	2-72
*DS7833	DS8833	Quad TRI-STATE Bus Transceiver	2-75
*DS7834	DS8834	Quad TRI-STATE Bus Transceiver	2-79
*DS7835	DS8835	Quad TRI-STATE Bus Transceiver	2-75
*DS7836	DS8836	Quad NOR Unified Bus Transceiver	2-83
*DS7837	DS8837	Hex Unified Bus Receiver	2-85
*DS7838	DS8838	Quad Unified Bus Transceiver	2-87
*DS7839	DS8839	Quad TRI-STATE Bus Transceiver	2-79
DS8T26AM	DS8T26A	4-Bit Bidirectional Bus Transceiver	2-89
*DS8T28M	DS8T28	4-Bit Bidirectional Bus Transceiver	2-89
DM54S240	DM74S240	Octal TRI-STATE Line Driver/Receiver	LOGIC
DM54S241	DM74S241	Octal TRI-STATE Line Driver/Receiver	LOGIC

<sup>\*</sup>Also available screened in accordance with MIL-STD-883 Class B. Refer to National Semiconductor's "The Reliability Handbook".



should be in the form of twisted pair or flat cable where a signal wire is alternated with a ground wire.

#### **OPEN-COLLECTOR BUS CIRCUITS**

Bus D	river		Bus Rec	eiver		Driver/		Device	Number		
Propagation Delay (ns)	V <sub>IL</sub> (V)/	Propagation Delay (ns)	V <sub>IL</sub> (V)/ I <sub>IL</sub> (μΑ)	V <sub>IH</sub> (V)/ I <sub>IH</sub> (μA)	Hysteresis (V)	Receiver/ Transceiver	Circuits/ Package	Commercial 0°C to +70°C	1 , 1		Page No.
		23	1.2/-50	1.8/50		Receiver	4	DS8640	DS7640	Quad NOR receiver	2-68
	ĺ	20	1.05/50	2.65/50	1	Receiver	4	DS8836	DS7836	Quad NOR receiver	2-83
		20	1.05/-50	2.65/50	1	Receiver	6	DS8837	DS7837		2-85
30	0.9/100	40	1.50/400	1.9/100		Transceiver	4	DS3662	,	Trapezoidal transceiver	2-29
30	0.7/50	30	1.2/-100	1.8/100		Transceiver -	4	DS8641	DS7641		2-70
20	0.7/50	17	1.05/-100	2.65/100	1	Transceiver	4	DS8642			2-72
20	0.8/100	20	1.3/-40	3.1/450		Transceiver	4	DS8838	DS7838	50Ω coax. driver	2-87
10	0.8/100	10	1.75/-100	2.25/100		Transceiver	4	DS26S10	DS26S10M		2-24
10	0.8/100	10	1.75/-100	2.25/100		Transceiver	4	DS26S11	DS26S11M	Input to bus is non-inverting	2-24
8	0.5/50	7	0.8/-500	2/100		Transceiver	4	DS36147	DS16147	Quad bidirectional I/O register	6-35
8	0.5/50	7	0.8/-500	2/100		Transceiver	4	DS36177	DS16177	Quad bidirectional I/O register	6-35
20	0.7/300					Driver	2	DS75450	DS55450	AND separate output transistors	3-51
18	0.7/300					Driver	2	DS75451	DS55451	AND	3-51
26	0.7/300					Driver	2	DS75452	DS55452	NAND	3-51
18	0.7/300	i			1	Driver	2	DS75453	DS55453	OR	3-51
27	0.7/300					Driver	2	DS75454	DS55454	NOR	3-51
		30	0.95/50	2/50	0.65	Receiver	1	DM8131	DM7131	6 bit bus comparator	LOGIC
	[	30	0.95/50	2/50	0.65	Receiver	1	DM8136	DM7136	6 bit bus comparator	LOGIC

## **Selection Guide**

## TRI-STATE® BUS CIRCUITS

	Bus Driver			Bus Rec	eiver						·	
Propagation Delay Typ (ns)	V <sub>OL</sub> (V)/ I <sub>OL</sub> (mA)	V <sub>OH</sub> (V)/ I <sub>OH</sub> (mA)	Propagation Delay Typ (ns)	V <sub>IL</sub> (V)/ I <sub>IL</sub> (μA)	V <sub>IH</sub> (V)/ I <sub>IH</sub> (μΑ)	Hysteresis (mV)	Driver/ Receiver/ Transceiver	Circuits/ Package	Devic Commercial 0°C to +70°C	e Number Military -55°C to +125°C	Comments	Page No.
14	0.5/50	2.4/—10	20	0.8/-40	2/80	400	Transceiver	4	DS8833	DS7833	Non-inverting TRI-STATE receiver	2-75 .
14	0.5/50	2.4/—10	20	0.8/-40	2/80	400	Transceiver	4	DS8835	DS7835	Inverting TRI-STATE receiver	2-75
14	0.5/50	2.4/—10	20	0.8/-40	2/80	400	Transceiver	4	DS8834	D\$7834	Inverting	2-79
14	0.5/50	2.4/-10	20	0.8/-40	2/80	400	Transceiver	4	DS8839	DS7839	Non-inverting	2-79
14	0.5/48	2.4/—10	14	0.85/-200	2/20		Transceiver	4	DS8T26A	DS8T26AM	Inverting	2-89
17	0.5/48	2.4/10	17	0.85/-200	2/20	l	Transceiver	4	DS8T28	DS8T28M	Non-inverting	2-89
20	0.6/55	3.6/—1	15	0.95/-250	2/10		Transceiver	4	DP8216	DP8216M	8080 MPU non-inverting	8-11
16	0.6/50	3.6/—1	15	0.95/-250	2/10		Transceiver	4	DP8226	DP8226M	8080 MPU inverting	8-11
4.5	0.55/64	2.4/-3	4.5	0.8/-400	2/50	400	Transceiver	4 or 8	DM74S240	DM54S240	Non-Inverting	LOGIC
6	0.55/64	2.4/-3	6	0.8/-400	2/50	400	Transceiver	4 or 8	DM74S241	DM54S241	Inverting	LOGIC
4.5	0.55/64	2.4/-3	4.5	0.8/-400	2/50	400	Transceiver	8	DM74S940	DM54S940	Non-Inverting	LOGIC
6	0.55/64	2.4/-3	6	0.8/-400	2/50	400	Transceiver	8	DM74S941	DM54S941	Inverting	LOGIC
8	0.5/50	2.4/-5	7	0.8/-500	2/100	,	Transceiver	4	DS3647	DS1647	Quad bidirectional I/O register	6-35
8	0.5/50	2.4/-5	7	0.8/-500	2/100		Transceiver	4	DS3677	DS1677	Quad bidirectional I/O register	6-35
10	0.5/50	3.6/-5	15	0.8/—250	2/80		Transceiver	8	DP8304B	DP7304B	Bidirectional non-inverting IEEE 488	2-5, 2-11
10	0.5/50	3.6/-5	10	0.8/-250	2/80		Transceiver	8	DP8303	DP7303	Bidirectional inverting	2-5, 2-6
10	0.5/50	3.6/-5	10	0.8/-250	2/80		Transceiver	8	DP8307	DP7307	Bidirectional inverting	2-5, 2-16
11	0.5/50	3.6/-5	15	0.8/-250	2/80		Transceiver	8	DP8308	DP7308	Bidirectional non-inverting	2-5, 2-2
20	0.45/15	3.6/1	<b>\</b>			[.	Driver	8	DP8212	DP8212M	8080 MPU data latch and service request f/f	8-4
30	0.45/10	2.4/-1	20	0.8/-250	2/20		Transceiver	8	DP8228	DP8228M	8080 MPU system bus controller and bus driver	8-22
30	0.45/10	2.4/1	20	0.8/-250	2/20		Transceiver	8	DP8238	DP8238M	8080 MPU system bus controller and bus driver	8-22
20	0.5/48	2.5/-5.2	20	0.8/-100	2/20	400	Transceiver	8	DS3666	-	IEEE 488 GPIB	2-48
20	0.5/48	2.5/-5.2	20	0.8/-100	2/20	400	Transceiver	8	DS3667			2-56
20	0.5/48	2.5/5.2	20	0.8/100	2/20	400	Transceiver	8	DS75160A		IEEE 488 GPIB	2-61
20	0.5/48	2.5/5.2	20	0.8/-100	2/20	400	Transceiver	8	DS75161A	. 1	IEEE 488 GPIB	2-61
20	0.5/48	2.5/-5.2	20	0.8/-100	2/20	400	Transceiver	8	DS75162A		IEEE 488 GPIB	2-61

Note, Unless otherwise specified, bus circuits listed above are TTL compatible and use 5V supplies



## 8-Bit TRI-STATE® Bidirectional Transceivers

DP7303/DP8303 (Inverting) with Transmit/Receive and Chip Disable Control Inputs DP7304B/DP8304B (Non-Inverting) with Transmit/Receive and Chip Disable Control Inputs DP7307/DP8307 (Inverting) with Transmit and Receive Control Inputs DP7308/DP8308 (Non-Inverting) with Transmit and Receive Control Inputs

### **General Description**

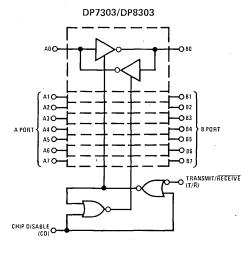
This family of 8 high speed Schottky 8-bit TRI-STATE bidirectional transceivers are designed to provide bidirectional drive for bus oriented microprocessor and digital communications systems. They are all capable of sinking 16 mA on the A ports and 48 mA on the B ports (bus ports). PNP inputs for low input current and an increased output high (VOH) level allow compatibility with MOS, CMOS, and other technologies that have a higher threshold and less drive capabilities. In addition, they all feature glitch-free power up/down

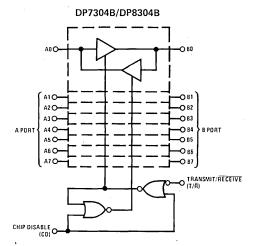
on the B port preventing erroneous glitches on the system bus in power up or down.

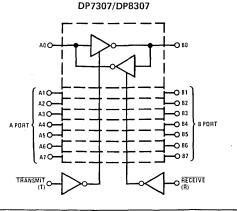
**Bus Transceivers** 

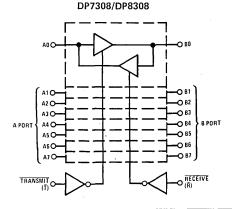
DP7303/DP8303 and DP7304B/DP8304B are featured with Transmit/Receive (T/ $\overline{R}$ ) and Chip Disable (CD) inputs to simplify control logic. For greater design flexibility, DP7307/DP8307 and DP7308/DP8308 are featured with Transmit ( $\overline{T}$ ) and Receive ( $\overline{R}$ ) control inputs

### Logic Diagrams









# National Semiconductor

## **Bus Transceivers**

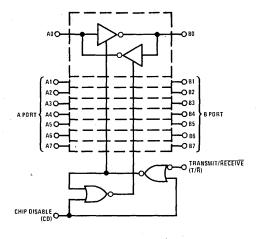
## DP7303/DP8303 8-Bit TRI-STATE® Bidirectional Transceiver (Inverting)

#### **Features**

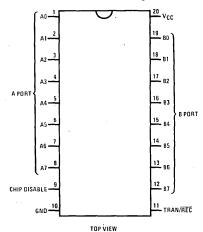
- 8-bit bidirectional data flow reduces system package count
- Bidirectional TRI-STATE inputs/outputs interface with bus oriented systems
- PNP inputs reduce input loading
- Output high voltage interfaces with TTL, MOS, and CMOS
- 48 mA/300 pF bus drive capability

- Pinouts simplify system interconnections
- Transmit/Receive and chip disable simplify control logic
- Compact 20-pin dual-in-line package
- Bus port glitch free power up/down

### Logic and Connection Diagrams



#### **Dual-In-Line Package**



Order Number DP7303J, DP8303J, or DP8303N See NS Package J20A or N20A

## Logic Table

IN.	IPUTS	RESULTING CONDITIONS				
Chip Disable	Chip Disable Transmit/Receive		B Port			
0	0	OUT	IN			
0	1	IN	OUT			
1	X	TRI-STATE	TRI-STATE			

X = Don't care

Absolute Maximum Ratings	(Note 1)	Recommended C	Operating	g Condi	itions
Supply Voltage Input Voltage Output Voltage	7 V 5.5 V 5.5 V	Supply Voltage (V <sub>CC</sub> )	Min	Max	Units
•	5°C to +150°C	DP7303 DP8303	4.5 4.75	5.5 5.25	v v
Cavity Package Molded Package	1667 mW 1832 mW	Temperature (T <sub>A</sub> ) DP7303	-55	125	°c
Lead Temperature (soldering, 10 seconds) *Derate cavity package 11.1 mW/°C above 25°C package 14.7 mW/°C.		DP8303	0	70	°C

## DC Electrical Characteristics (Notes 2 and 3)

	Parameter	Coi	nditio	ıs	Min	Тур	Max	Units
A Port (A	0-A7)						,	
VIH	Logical "1" Input Voltage	CD = V <sub>IL</sub> , T/R = :	2.0V		2.0			٧
VIL	Logical "0" Input Voltage	CD = V <sub>IL</sub> , T/R = :	2.0V	DP8303			0.8	٧
				DP7303			0.7	٧
VOH	Logical "1" Output Voltage	$CD = T/\overline{R} = V_{IL}$		I <sub>OH</sub> = -0.4 mA	V <sub>CC</sub> -1.15	V <sub>CC</sub> -0.7		٧
				IOH = -3 mA	2.7	3.95		٧
VOL	Logical "0" Output Voltage	CD = T/R = VIL	IOL =	= 16 mA (8303)		0.35	0.5	٧
			IOL =	8 mA (both)		0.3	0.4	>
los	Output Short Circuit Current	$CD = V_{IL}$ , $T/\overline{R} = V_{IL}$ , $V_O = 0V$ , $V_{CC} = max$ , Note 4		-10	-38	-75	mA	
lіН	Logical "1" Input Current	CD = V <sub>IL</sub> , T/R = 2.0V, V <sub>IH</sub> = 2.7V			0.1	80	μΑ	
11	Input Current at Maximum Input Voltage	CD = 2.0V, V <sub>CC</sub> = max, V <sub>IH</sub> = 5.25V			/	1	mA	
IIL	Logical "0" Input Current	$CD = V_{IL}, T/\overline{R} = 3$	2.0V,	V <sub>IN</sub> = 0.4V		-70	-200	μΑ
VCLAMP	Input Clamp Voltage	CD = 2.0 V, I <sub>IN</sub> = -12 mA			-0.7	-1.5	٧	
IOD Output/Input		CD = 2.0 V		V <sub>IN</sub> = 0.4 V			-200	μΑ
	TRI-STATE Current			V <sub>IN</sub> = 4.0V			80	μΑ
B Port (B	0-B7)		-					
VIH	Logical "1" Input Voltage	CD = V <sub>IL</sub> , T/R = 1	VIL.		2.0			٧
VIL	Logical "0" Input Voltage	CD = V <sub>IL</sub> , T/R = 1	CD = V <sub>IL</sub> , T/R = V <sub>IL</sub> DP8303				0.8	٧
				DP7303			0.7	٧
Voн	Logical "1" Output Voltage	$CD = V_{IL}, T/\overline{R} = 2$	2.0V	IOH = -0.4 mA	V <sub>CC</sub> -1.15	V <sub>CC</sub> -0.8		٧
				10H = -5 mA	2.7	3.9		٧
				IOH = -10 mA	2.4	3.6		٧
VOL	Logical "0" Output Voltage	CD = V <sub>IL</sub> , T/R = :	2.0V	I <sub>OL</sub> = 20 mA		0.3	0.4	٧
				IOL = 48 mA		0.4	0.5	٧
los	Output Short Circuit Current	CD = $V_{IL}$ , $T/\overline{R}$ = : $V_{CC}$ = max, Note		V <sub>O</sub> = 0V,	-25	-50	-150	mA
Ιн	Logical "1" Input Current	CD = VIL, T/R = V	VIL, V	'IH = 2.7V	,	0.1	80	μΑ
IĮ.	Input Current at Maximum Input Voltage	CD = 2.0V, V <sub>CC</sub> =	= max,	V <sub>IH</sub> = 5.25V			1	mA
IIL	Logical "0" Input Current	CD = V <sub>IL</sub> , T/R = '	VIL, V	'IN = 0.4V		-70	-200	μΑ
VCLAMP	Input Clamp Voltage	CD = 2.0V, I <sub>IN</sub> =	-12 m	A		-0.7	-1.5	٧
IOD	Output/Input	CD = 2.0 V		V <sub>IN</sub> = 0.4 V			-200	μΑ
	TRI-STATE Current			V <sub>IN</sub> = 4.0V			+200	μΑ

## DC Electrical Characteristics (cont'd.) (Notes 2 and 3)

	Parameter	Cor	nditions	Min	Тур	Max	Units
Contro	I Inputs CD, T/R						
VIH	Logical "1" Input Voltage			2.0			٧
VIL	VIL Logical "0" Input Voltage		DP8303			0.8	V
			DP7303			0.7	٧
ΉΗ	Logical "1" Input Current	V <sub>IH</sub> = 2.7 V			0.5	20	μΑ
lį.	Maximum Input Current	VCC = max, VIH =	= 5.25V			1.0	mA
IIL	Logical "0" Input Current	V <sub>IL</sub> = 0.4V	T/R		-0.1	-0.25	mA
*			CD		-0.25	-0.5	mA
VCLA	MP Input Clamp Voltage	IIN = -12 mA			-0.8	-1.5	٧
Power	Supply Current						
Icc	Power Supply Current	CD = 2.0V = V <sub>IN</sub> ,		70	100	mΑ	
		CD = 0.4V, VINA		100	150	mA	

## AC Electrical Characteristics V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C

	Parameter	Conditions	Min	Тур	Max	Units
A Port Da	ita/Mode Specifications					
tPDHLA	Propagation Delay to a Logical "0" from B Port to A Port	CD = $0.4 \text{ V}$ , $T/\overline{R} = 0.4 \text{ V}$ (figure A) R1 = 1k, R2 = 5k, C1 = 30 pF		8	12	ns
<sup>t</sup> PDLHA	Propagation Delay to a Logical "1" from B Port to A Port	CD = $0.4 \text{ V}$ , $T/\overline{R} = 0.4 \text{ V}$ (figure A) R1 = 1k, R2 = 5k, C1 = 30 pF		11	16	ns
<sup>t</sup> PLZA	Propagation Delay from a Logical "0" to TRI-STATE from CD to A Port	B0 to B7 = $2.4 \text{ V}$ , $T/\overline{R}$ = $0.4 \text{ V}$ (figure C) S3 = 1, R5 = 1k, C4 = $15 \text{ pF}$		10	15	ns
<sup>t</sup> PHZA	Propagation Delay from a Logical "1" to TRI-STATE from CD to A Port	B0 to B7 = $0.4 \text{ V}$ , $T/\overline{R}$ = $0.4 \text{ V}$ (figure C) S3 = 0, R5 = 1k, C4 = 15 pF		8	15	ns
<sup>t</sup> PZLA	Propagation Delay from TRI-STATE to a Logical "0" from CD to A Port	B0 to B7 = 2.4 V, $T/\overline{R}$ = 0.4 V (figure C) S3 = 1, R5 = 1k, C4 = 30 pF		20	30	ns
<sup>t</sup> PZHA	Propagation Delay from TRI-STATE to a Logical "1" from CD to A Port	B0 to B7 = $0.4 \text{ V}$ , $T/\overline{R} = 0.4 \text{ V}$ (figure C) S3 = 0, R5 = 5k, C4 = 30 pF		19	30	ns
B Port Da	ita/Mode Specifications					
<sup>t</sup> PDHLB	Propagation Delay to a Logical "0" from A Port to B Port	CD = $0.4$ V, $T/\overline{R}$ = $2.4$ V (figure A) R1 = $100 \Omega$ , R2 = 1k, C1 = $300 \text{ pF}$ R1 = $667 \Omega$ , R2 = $5$ k, C1 = $45 \text{ pF}$		12 7	18 12	ns ns
<sup>t</sup> PDLHB	Propagation Delay to a Logical "1" from A Port to B Port	CD = 0.4 V, T/ $\overline{R}$ = 2.4 V (figure A) R1 = 100 $\Omega$ , R2 = 1k, C1 = 300 pF R1 = 667 $\Omega$ , R2 = 5k, C1 = 45 pF		15 9	20 14	ns ns
tPLZB	Propagation Delay from a Logical "0" to TRI-STATE from CD to B Port	A0 to A7 = 2.4 V, $T/\overline{R}$ = 2.4 V (figure C) S3 = 1, R5 = 1k, C4 = 15 pF		13	18	ns
<sup>t</sup> PHZB	Propagation Delay from a Logical "1" to TRI-STATE from CD to B Port	A0 to A7 = $0.4$ V, $T/\overline{R}$ = 2.4 V (figure C) S3 = 0, R5 = 1k, C4 = 15 pF		8	15	ns
<sup>t</sup> PZLB	Propagation Delay from TRI-STATE to a Logical "O" from CD to B Port	A0 to A7 = 2.4 V, $T/\overline{R}$ = 2.4 V (figure C) S3 = 1, R5 = 100 $\Omega$ , C4 = 300 pF S3 = 1, R5 = 667 $\Omega$ , C4 = 45 pF		25 16	35 25	ns ns
<sup>t</sup> PZHB	Propagation Delay from TRI-STATE to a Logical "1" from CD to B Port	A0 to A7 = 0.4 V, T/R = 2.4 V (figure C) S3 = 0, R5 = 1k, C4 = 300 pF S3 = 0, R5 = 5k, C4 = 45 pF	-	22 14	35 25	ns ns

## AC Electrical Characteristics (cont'd.) $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$

	Parameter	Conditions	Min	Тур	Max	Units
Transm	it/Receive Mode Specifications			-		
tTRL	Propagation Delay from Transmit Mode to Receive a Logical "0," $T/\overline{R}$ to A Port	CD = 0.4 V (figure B) S1 = 1, R4 = $100 \Omega$ , C3 = $5 pF$ S2 = 1, R3 = $1k$ , C2 = $30 pF$		23	35	ns
tTRH	Propagation Delay from Transmit Mode to Receive a Logical "1," $T/\overline{R}$ to A Port	CD = 0.4 V (figure B) S1 = 0, R4 = 100 $\Omega$ , C3 = 5 pF S2 = 0, R3 = 5k, C2 = 30 pF		22	35	ns
<sup>t</sup> RTL	Propagation Delay from Receive Mode to Transmit a Logical "0," T/R to B Port	CD = 0.4 V (figure B) S1 = 1, R4 = $100 \Omega$ , C3 = $300 pF$ S2 = 1, R3 = $300 \Omega$ , C2 = $5 pF$		26	35	ns
<sup>t</sup> RTH	Propagation Delay from Receive Mode to Transmit a Logical "1," $T/\overline{R}$ to B Port	CD = 0.4 V (figure B) S1 = 0, R4 = 1k, C3 = 300 pF S2 = 0, R3 = 300 $\Omega$ , C2 = 5 pF		27	35	ns

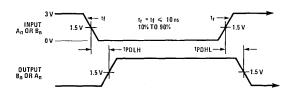
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

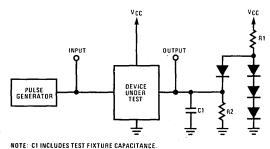
Note 2: Unless otherwise specified, min/max limits apply across the supply and temperature range listed in the table of Recommended Operating Conditions. All typical values given are for  $V_{CC} = 5V$  and  $T_A = 25^{\circ}C$ .

Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise specified.

Note 4: Only one output at a time should be shorted.

### Switching Time Waveforms and AC Test Circuits

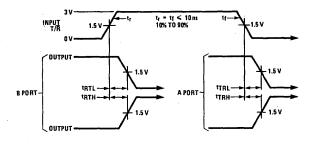


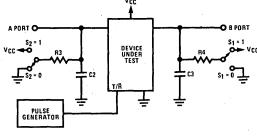


MOTE: CTINCEODES TEST FIXTURE CAPACITANCE.

FIGURE A. Propagation Delay from A Port to B Port or from B Port to A Port

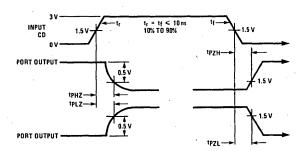
## Switching Time Waveforms and AC Test Circuits (cont'd.)





NOTE: C2 AND C3 INCLUDE TEST FIXTURE CAPACITANCE.

FIGURE B. Propagation Delay from  $T/\overline{R}$  to A Port or B Port



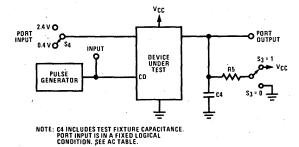


FIGURE C. Propagation Delay to/from TRI-STATE® from CD to A Port or B Port



## **Bus Transceivers**

## DP7304B/DP8304B 8-Bit TRI-STATE® Bidirectional Transceiver (Non-Inverting)

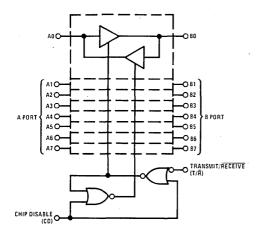
#### **Features**

DP7304B/DP8304B

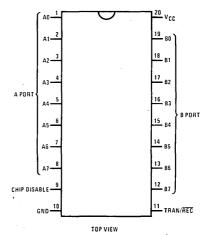
- 8-bit bidirectional data flow reduces system package count
- Bidirectional TRI-STATE inputs/outputs interface with bus oriented systems
- PNP inputs reduce input loading
- Output high voltage interfaces with TTL, MOS, and CMOS
- 48 mA/300 pF bus drive capability

- Pinouts simplify system interconnections
- Transmit/Receive and chip disable simplify control logic
- Compact 20-pin dual-in-line package
- Bus port glitch free power up/down

## **Logic and Connection Diagrams**



#### Dual-In-Line Package



Order Number DP7304BJ, DP8304BJ, or DP8304BN See NS Package J20A or N20A

## Logic Table

IN	IPUTS	RESULTING CONDITIONS			
Chip Disable	Chip Disable Transmit/Receive		B Port		
0	0	OUT	IN		
0	1	IN ·	OUT		
1	X	TRI-STATE	TRI-STATE		

X = Don't care

Absolute Maximum Ratings	(Note 1)	Recommended (	Operating	g Condi	tions
Supply Voltage Input Voltage Output Voltage Storage Temperature -65° Maximum Power Dissipation* at 25°C	7 V 5.5 V 5.5 V C to +150° C	Supply Voltage (VCC) DP7304B DP8304B	Min 4.5 4.75	Max 5.5 5.25	Units V V
Cavity Package Molded Package Lead Temperature (soldering, 10 seconds) *Derate cavity package 11.1 mW/°C above 25°C; d package 14.7 mW/°C above 25°C.	1667 mW 1832 mW 300°C erate molded	Temperature (T <sub>A</sub> ) DP7304B DP8304B	-55 0	- 125 70	°C °C

DC Electrical Characteristics (Notes 2 and 3)

	Parameter	Conditi	ons	Min	Тур	Max	Unit
A Port (A	(0-A7)			,			
VIH	Logical "1" Input Voltage	CD = V <sub>IL</sub> , T/R = 2.0V		2.0			٧٠
VIL	Logical "0" Input Voltage	$CD = V_{IL}, T/\overline{R} = 2.0V$	DP8304B			0.8	٧
			DP7304B			0.7	٧
Vон	Logical "1" Output Voltage	$CD = V_{IL}, T/\overline{R} = V_{IL}$	I <sub>OH</sub> = -0.4 mA	V <sub>CC</sub> -1.15	V <sub>CC</sub> -0.7		٧
			IOH = -3 mA	2.7	3.95		٧
VoL	Logical "0" Output Voltage	CD = T/R = VIL IOL	= 16 mA (8304B)	·	0.35	0.5	٧
			= 8 mA (both)		0.3	0.4	V
Ios	Output Short Circuit Current	CD = $V_{IL}$ , $T/\overline{R} = V_{IL}$ , $V_O = 0V$ , $V_{CC} = max$ , Note 4		-10	-38	<b>-</b> 75	mA
Ιн	Logical "1" Input Current	$CD = V_{1L}, T/\overline{R} = 2.0V, V_{1H} = 2.7V$			0.1	80	μΑ
li .	Input Current at Maximum Input Voltage	CD = 2.0 V, V <sub>CC</sub> = ma			1	mA	
IIL	Logical "0" Input Current	$CD = V_{IL}$ , $T/\overline{R} = 2.0V$		<del>-</del> 70	-200	μΑ	
VCLAMP	Input Clamp Voltage	CD = 2.0 V, I <sub>IN</sub> = -12 mA			-0.7	-1.5	٧
IOD Output/Input		CD = 2.0 V	V <sub>IN</sub> = 0.4 V			-200	μΑ
	TRI-STATE Current		V <sub>IN</sub> = 4.0 V			80	μΑ
B Port (B	0-B7)			_			
VIH	Logical "1" Input Voltage	$CD = V_{IL}$ , $T/\overline{R} = V_{IL}$		2.0			٧
VIL	Logical "0" Input Voltage	$CD = V_{IL}, T/\overline{R} = V_{IL}$	DP8304B			0.8	V
			DP7304B			0.7	>
Vон	Logical "1" Output Voltage	$CD = V_{IL}, T/\overline{R} = 2.0V$	1 <sub>OH</sub> = -0.4 mA	V <sub>CC</sub> -1.15	VCC-0.8		٧
		•	$I_{OH} = -5  \text{mA}$	2.7	3.9		٧
			IOH = -10 mA	2.4	3.6		V
VoL	Logical "0" Output Voltage	$CD = V_{IL}, T/\overline{R} = 2.0V$	I <sub>OL</sub> = 20 mA		0.3	0.4	>
			IOL = 48 mA		0.4	0.5	٧
los	Output Short Circuit Current	CD = $V_{1L}$ , $T/\vec{R}$ = 2.0V $V_{CC}$ = max, Note 4	, V <sub>O</sub> = 0V,	-25	-50	-150	mA
Iн	Logical "1" Input Current	$CD = V_{IL}, T/\overline{R} = V_{IL},$	V <sub>IH</sub> = 2.7V		0.1	80	μΑ
II.	Input Current at Maximum Input Voltage	CD = 2.0 V, V <sub>CC</sub> = ma	x, V <sub>IH</sub> = 5.25V			1	mA
ЦL	Logical "0" Input Current	$CD = V_{IL}, T/\overline{R} = V_{IL},$	V <sub>IN</sub> = 0.4V		-70	-200	μΑ
VCLAMP	Input Clamp Voltage	CD = 2.0V, I <sub>IN</sub> = -12	mA		-0.7	-1.5	V
IOD	Output/Input	CD = 2.0 V	V <sub>IN</sub> = 0.4 V			-200	μΑ
	TRI-STATE Current	V <sub>IN</sub> = 4.0 V				+200	μΑ

## DC Electrical Characteristics (cont'd.) (Notes 2 and 3)

	Parameter	Cor	nditions	Min	Тур	Max	Units
Control	Inputs CD, T/R						
VIH	Logical "1" Input Voltage			2.0			٧
VIL	Logical "0" Input Voltage		DP8304B			0.8	V
			DP7304B	,		0.7	٧
ПН	Logical "1" Input Current	V <sub>IH</sub> = 2.7 V			0.5	20	μΑ
IJ	Maximum Input Current	VCC = max, VIH = 5.25 V				. 1.0	mA
IIL.	Logical "0" Input Current	V <sub>IL</sub> = 0.4 V	T/R		-0.1	-0.25	mA
•		,	CD		-0.25	-0.5	mA
VCLAN	лр Input Clamp Voltage	I <sub>IN</sub> = -12 mA			-0.8	-1.5	٧
Power 9	Supply Current						
Icc	Power Supply Current	CD = 2.0 V, V <sub>IN</sub> =	0.4 V , V <sub>CC</sub> = max		70	100	mA
		CD = V <sub>INA</sub> = 0.4\	/, T/R = 2V, V <sub>CC</sub> = max	2.1.2.1.	90	140	mA

## AC Electrical Characteristics $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$

	Parameter	Conditions	Min	Тур	Max	Units
A Port Da	ata/Mode Specifications					
tPDHLA	Propagation Delay to a Logical "0" from B Port to A Port	CD = $0.4 \text{ V}$ , $T/\overline{R} = 0.4 \text{ V}$ (figure A), R1 = 1k, R2 = 5k, C1 = 30 pF	14		18	ns
<sup>t</sup> PDLHA	Propagation Delay to a Logical "1" from B Port to A Port	CD = $0.4 \text{ V}$ , $T/\overline{R} = 0.4 \text{ V}$ (figure A) R1 = 1k, R2 = 5k, C1 = 30 pF		13	18	ns
<sup>t</sup> PLZA	Propagation Delay from a Logical "0" to TRI-STATE from CD to A Port	B0 to B7 = $0.4 \text{ V}$ , $T/\overline{R}$ = $0.4 \text{ V}$ (figure C) S3 = 1, R5 = 1k, C4 = 15 pF		11	15	ns
tPHZA	Propagation Delay from a Logical "1" to TRI-STATE from CD to A Port	B0 to B7 = 2.4 V, $T/\overline{R}$ = 0.4 V (figure C) S3 = 0, R5 = 1k, C4 = 15 pF		8	15	ņs
<sup>t</sup> PZLA	Propagation Delay from TRI-STATE to a Logical "0" from CD to A Port	B0 to B7 = 0.4 V, $T/\overline{R}$ = 0.4 V (figure C) S3 = 1, R5 = 1k, C4 = 30 pF		27	35	ns
<sup>t</sup> PZHA	Propagation Delay from TRI-STATE to a Logical "1" from CD to A Port	B0 to B7 = $2.4 \text{ V}$ , $T/\overline{R}$ = $0.4 \text{ V}$ (figure C) S3 = $0$ , R5 = $5\text{k}$ , C4 = $30 \text{ pF}$		19	25	ns
B Port Da	nta/Mode Specifications					
tPDHLB	Propagation Delay to a Logical "0" from A Port to B Port	CD = 0.4 V, $T/\overline{R}$ = 2.4 V (figure A) R1 = 100 $\Omega$ , R2 = 1k, C1 = 300 pF R1 = 667 $\Omega$ , R2 = 5k, C1 = 45 pF		18 11	23 18	ns ns
<sup>t</sup> PDLHB	Propagation Delay to a Logical "1" from A Port to B Port	CD = 0.4 V, $T/\vec{R}$ = 2.4 V (figure A) R1 = 100 $\Omega$ , R2 = 1k, C1 = 300 pF R1 = 667 $\Omega$ , R2 = 5k, C1 = 45 pF		16 11	23 18	ns ns
<sup>t</sup> PLZB	Propagation Delay from a Logical "0" to TRI-STATE from CD to B Port	A0 to A7 = 0.4 V, $T/\overline{R}$ = 2.4 V (figure C) S3 = 1, R5 = 1k, C4 = 15 pF		13	18	ns
<sup>†</sup> PHZB	Propagation Delay from a Logical "1" to TRI-STATE from CD to B Port	A0 to A7 = 2.4 V, $T/\overline{R}$ = 2.4 V (figure C) S3 = 0, R5 = 1k, C4 = 15 pF		8	15	ns
<sup>t</sup> PZLB	Propagation Delay from TRI-STATE to a Logical "O" from CD to B Port	A0 to A7 = 0.4 V, $T/\overline{R}$ = 2.4 V (figure C) S3 = 1, R5 = 100 $\Omega$ , C4 = 300 pF S3 = 1, R5 = 667 $\Omega$ , C4 = 45 pF		32 16	40 22	ns ns
<sup>†</sup> PZHB	Propagation Delay from TRI-STATE to a Logical "1" from CD to B Port	A0 to A7 = 2.4 V, $T/\overline{R}$ = 2.4 V (figure C) S3 = 0, R5 = 1k, C4 = 300 pF S3 = 0, R5 = 5k, C4 = 45 pF		26 14	35 22	ns ns

## AC Electrical Characteristics (cont'd.) V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C

	Parameter	Conditions	Min	Тур	Max	Units
Transm	it/Receive Mode Specifications					
<sup>t</sup> TRL	Propagation Delay from Transmit Mode to Receive a Logical "0," $T/\overline{R}$ to A Port	CD = 0.4 V (figure B) S1 = 0, R4 = $100 \Omega$ , C3 = $5 pF$ S2 = 1, R3 = $1k$ , C2 = $30 pF$		30	40	ns
tTRH	Propagation Delay from Transmit Mode to Receive a Logical "1," $T/\overline{R}$ to A Port	CD = 0.4 V (figure B) S1 = 1, R4 = $100 \Omega$ , C3 = $5 pF$ S2 = 0, R3 = $5k$ , C2 = $30 pF$		28	40	ns
<sup>t</sup> RTL	Propagation Delay from Receive Mode to Transmit a Logical "0," T/R to B Port	CD = 0.4 V (figure B) S1 = 1, R4 = $100 \Omega$ , C3 = $300 pF$ S2 = 0, R3 = $300 \Omega$ , C2 = $5 pF$		31	40	ns
<sup>t</sup> RTH	Propagation Delay from Receive Mode to Transmit a Logical "1," T/R to B Port	CD = 0.4 V (figure B) S1 = 0, R4 = 1k, C3 = 300 pF S2 = 1, R3 = 300 Ω, C2 = 5 pF		28	40	ns

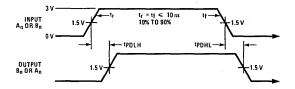
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

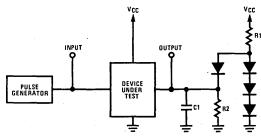
Note 2: Unless otherwise specified, min/max limits apply across the supply and temperature range listed in the table of Recommended Operating Conditions. All typical values given are for V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C.

Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise specified.

Note 4: Only one output at a time should be shorted.

## Switching Time Waveforms and AC Test Circuits

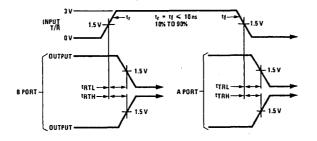




NOTE: C1 INCLUDES TEST FIXTURE CAPACITANCE.

FIGURE A. Propagation Delay from A Port to B Port or from B Port to A Port

## Switching Time Waveforms and AC Test Circuits (cont'd.)



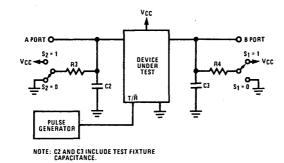
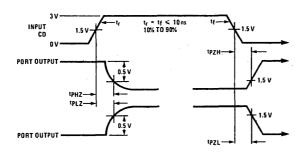


FIGURE B. Propagation Delay from T/R to A Port or B Port



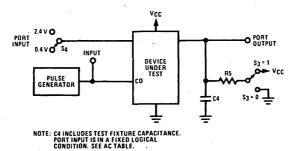


FIGURE C. Propagation Delay to/from TRI-STATE® from CD to A Port or B Port

# National Semiconductor

## **Bus Transceivers**

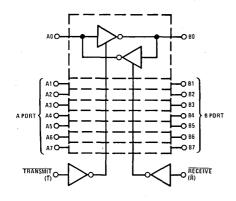
## DP7307/DP8307 8-Bit TRI-STATE® Bidirectional Transceiver (Inverting)

#### **Features**

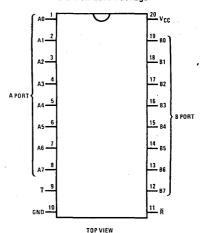
- 8-bit bidirectional data flow reduces system package count
- Bidirectional TRI-STATE inputs/outputs interface with bus oriented systems
- PNP inputs reduce input loading
- Output high voltage interfaces with TTL, MOS, and CMOS
- 48 mA/300 pF bus drive capability

- Pinouts simplify system interconnections
- Independent T and R controls for versatility
- Compact 20-pin dual-in-line package
- Bus port glitch free power up/down

## Logic and Connection Diagrams



#### **Dual-In-Line Package**



Order Number DP7307J, DP8307J or DP8307N See NS Package J20A or N20A

## Logic Table

CONTRO	L INPUTS	RESULTING CONDITIONS				
Transmit	Receive	A Port	B Port			
1	0	OUT	IN			
0	1	IN	OUT			
1	1	TRI-STATE	TRI-STATE			
0	0 _	Both Active*				

<sup>\*</sup>This is not an intended logic condition and may cause oscillations.

Absolute Maximum Ratings	(Note 1)	Recommended C	perating	g Condi	tions
Supply Voltage Input Voltage Output Voltage Storage Temperature Maximum Power Dissipation* at 25°C	7 V 5.5 V 5.5 V C to +150° C	Supply Voltage (VCC) DP7307 DP8307	Min 4.5 4.75	Max 5.5 5.25	Units V V
Cavity Package Molded Package Lead Temperature (soldering, 10 seconds) *Derate cavity package 11.1 mW/°C above 25°C; c package 14.7 mW/°C above 25°C.	1667 mW 1832 mW 300° C Jerate molded	Temperature (T <sub>A</sub> ) DP7307 DP8307	55 0	125 70	°C °C

## DC Electrical Characteristics (Notes 2 and 3)

	Parameter	Conditions		Min	Тур	Max	Unit	
A Port (A	0-A7)							
VIH	Logical "1" Input Voltage	$\overline{T} = V_{1L}$ , $\overline{R} = 2.0V$			2.0			V
VIL	Logical "0" Input Voltage	T = V <sub>IL</sub> , R = 2.0V		DP8307			0.8	٧
				DP7307			0.7	V
Vон	Logical "1" Output Voltage	T = 2.0V, R = VIL		$I_{OH} = -0.4 \text{ mA}$	V <sub>CC</sub> -1.15	V <sub>CC</sub> -0.7		V
				10H = -3 mA	2.7	3.95		٧
VoL	Logical "0" Output Voltage		IOL =	16 mA (8307)		0.35	0.5	V
		R = VIL	IOL =	8 mA (both)		0.3	0.4	٧
los	Output Short Circuit Current	$\overline{T}$ = 2.0V, $\overline{R}$ = V <sub>IL</sub> , V <sub>O</sub> = 0V, V <sub>CC</sub> = max, Note 4		-10	-38	-75	mA	
ΙΉ	Logical "1" Input Current	$\overline{T} = V_{IL}, \overline{R} = 2.0V$	, V <sub>IH</sub> =	2.7V		0.1	80	μΑ
Ц	Input Current at Maximum Input Voltage	$\overline{R} = \overline{T} = 2.0 \text{ V}, \text{ V}_{CC} = \text{max}, \text{ V}_{IH} = 5.25 \text{ V}$				1	mA	
IJĽ	Logical "0" Input Current	$\overline{T} = V_{IL}, \overline{R} = 2.0V$	$\overline{\Gamma} = V_{1L}, \overline{R} = 2.0V, V_{1N} = 0.4V$			-70	-200	μΑ
VCLAMP	Input Clamp Voltage	$\overline{T} = \overline{R} = 2.0 \text{ V}, I_{1N}$	= -12 r	nA		0.7	-1.5	٧
IOD	Output/Input	T = R = 2.0V		V <sub>IN</sub> = 0.4 V			-200	μΑ
	TRI-STATE Current			V <sub>IN</sub> = 4.0 V			80	μΑ
B Port (B	D-B7)							
VIH	Logical "1" Input Voltage	T= 2.0V, R = VIL			2.0			<b>V</b>
VIL	Logical "0" Input Voltage	$\overline{T}$ = 2.0V, $\overline{R}$ = V <sub>IL</sub>		DP8307			8.0	>
				DP7307			0.7	V
Voн	Logical "1" Output Voltage	$\overline{T} = V_{1L}$ , $\overline{R} = 2.0V$		$I_{OH} = -0.4  \text{mA}$	V <sub>CC</sub> -1.15	V <sub>CC</sub> -0.8		V
				I <sub>OH</sub> = -5 mA	2.7	3.9		٧
				$I_{OH} = -10  mA$	2.4	3.6		V
VoL	Logical "0" Output Voltage	$\overline{T} = V_{IL}$ , $\overline{R} = 2.0V$		I <sub>OL</sub> = 20 mA		0.3	0.4	٧
			Ī	IOL = 48 mA		0.4	0.5	٧
los	Output Short Circuit Current	$\overline{T} = V_{IL}$ , $\overline{R} = 2.0V$ $V_{CC} = max$ , Note		0V,	-25	-50	-150	mA
ΙΗ	Logical "1" Input Current	$\overline{T}$ = 2.0V, $\overrightarrow{R}$ = V <sub>IL</sub>	, V <sub>IH</sub> =	2.7V		0.1	80	μΑ
t <sub>l</sub>	Input Current at Maximum Input Voltage	$\overline{T} = \overline{R} = 2.0 \text{V}, \text{VCC}$	c = max	x, V <sub>IH</sub> = 5.25V			1	mA
liL.	Logical "0" Input Current	$\overline{T}$ = 2.0V, $\overline{R}$ = V <sub>IL</sub>	, V <sub>IL</sub> =	0.4V		-70	-200	μΑ
VCLAMP	Input Clamp Voltage	T = R = 2.0V, IIN	= -12 n	nA		-0.7	-1.5	V
lop	Output/Input	$\overrightarrow{T} = \overline{R} = 2.0 V$		V <sub>IN</sub> = 0.4 V			-200	μΑ
	TRI-STATE Current		Ī	V <sub>IN</sub> = 4.0 V			+200	μΑ

## DC Electrical Characteristics (cont'd.) (Notes 2 and 3)

	Parameter	Co	nditions	Min	Тур	Max	Units
Contro	l Inputs T, R						
VIH	Logical "1" Input Voltage			2.0			٧
VIL	Logical "0" Input Voltage		DP8307			8.0	٧
			DP7307			0.7	٧
I <sub>IH</sub>	Logical "1" Input Current	V <sub>IH</sub> = 2.7 V			0.5	20	μΑ
lį.	Maximum Input Current	VCC = max, VIH	VCC = max, VIH = 5.25V			1.0	mA
IJL	Logical "0" Input Current	V <sub>IL</sub> = 0.4 V	R		-0.1	-0.25	mA
			Ť		-0.25	-0.5	: mA
VCLA	MP Input Clamp Voltage	I <sub>IN</sub> = -12 mA			-0.8	-1.5	. V
Power	Supply Current						
Icc	Power Supply Current	T = R = 2.0V, VII	V = 2.0 V, VCC = max		70	100	mA
		T = 0.4 V, VINA =	= R = 2V, V <sub>CC</sub> = max		100	150	mA

## AC Electrical Characteristics V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C

	Parameter	Conditions	Min	Тур	Max	Units
A Port Da	ata/Mode Specifications					
<sup>t</sup> PDHLA	Propagation Delay to a Logical "0" from B Port to A Port	T = 2.4V, R = 0.4V (figure A) R1 = 1k, R2 = 5k, C1 = 30 pF		8		ns
<sup>t</sup> PDLHA	Propagation Delay to a Logical "1" from B Port to A Port	$\overline{T}$ = 2.4 V, $\overline{R}$ = 0.4 V (figure A) R1 = 1k, R2 = 5k, C1 = 30 pF	-	11	16	ns
<sup>t</sup> PLZA	Propagation Delay from a Logical "0" to TRI-STATE from $\overline{R}$ to A Port	B0 to B7 = 2.4 V, T = 2.4 V (figure B) S3 = 1, R5 = 1k, C4 = 15 pF		10	15	ns
<sup>t</sup> PHZA	Propagation Delay from a Logical "1" to TRI-STATE from $\overline{R}$ to A Port	B0 to B7 = 0.4 V, T = 2.4 V (figure B) S3 = 0, R5 = 1k, C4 = 15 pF		8	15	ns
<sup>t</sup> PZLA	Propagation Delay from TRI-STATE to a Logical "0" from $\overline{R}$ to A Port	B0 to B7 = 2.4 V, T = 2.4 V (figure B) S3 = 1, R5 = 1k, C4 = 30 pF		25	35	ns
<sup>t</sup> PZHA	Propagation Delay from TRI-STATE to a Logical "1" from $\overline{R}$ to A Port	B0 to B7 = 0.4 V, T = 2.4 V (figure B) S3 = 0, R5 = 5k, C4 = 30 pF		24	35	ns
B Port Da	ata/Mode Specifications	<u> </u>				
<sup>t</sup> PDHLB	Propagation Delay to a Logical "0" from A Port to B Port	$\overline{T}$ = 0.4 V, $\overline{R}$ = 2.4 V (figure A) R1 = 100 $\Omega$ , R2 = 1k, C1 = 300 pF R1 = 667 $\Omega$ , R2 = 5k, C1 = 45 pF		12 8	18 12	ns ns
<sup>†</sup> PDLHB	Propagation Delay to a Logical "1" from A Port to B Port	$\overline{T}$ = 0.4 V, $\overline{R}$ = 2.4 V (figure A) R1 = 100 $\Omega$ , R2 = 1k, C1 = 300 pF R1 = 667 $\Omega$ , R2 = 5k, C1 = 45 pF		15 9	-23 14	ns ns
<sup>t</sup> PLZB	Propagation Delay from a Logical "0" to TRI-STATE from $\overline{T}$ to B Port	A0 to A7 = 2.4 V, $\overline{R}$ = 2.4 V (figure B) S3 = 1, R5 = 1k, C4 = 15 pF		13	18	ns
tPHZB	Propagation Delay from a Logical "1" to TRI-STATE from $\overline{T}$ to B Port	A0 to A7 = 0.4 V, $\overline{R}$ = 2.4 V (figure B) S3 = 0, R5 = 1k, C4 = 15 pF		8	15	ns
tPZLB	Propagation Delay from TRI-STATE to a Logical "0" from $\overline{T}$ to B Port	A0 to A7 = 2.4 V, $\overline{R}$ = 2.4 V (figure B) S3 = 1, R5 = 100 $\Omega$ , C4 = 300 pF S3 = 1, R5 = 667 $\Omega$ , C4 = 45 pF	,	32 18	40 25	ns ns
<sup>t</sup> PZHB	Propagation Delay from TRI-STATE to a Logical "1" from $\overline{T}$ to B Port	A0 to A7 = 0.4 V, $\overline{R}$ = 2.4 V (figure B) S3 = 0, R5 = 1k, C4 = 300 pF S3 = 0, R5 = 5k, C4 = 45 pF		25 16	35 25	ns ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the supply and temperature range listed in the table of Recommended Operating Conditions. All typical values given are for  $V_{CC} = 5V$  and  $T_A = 25^{\circ}C$ .

Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise specified.

Note 4: Only one output at a time should be shorted.

### Switching Time Waveforms and AC Test Circuits

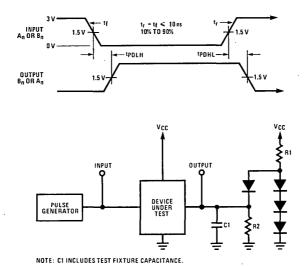


FIGURE A. Propagation Delay from A port to B port or from B port to A port

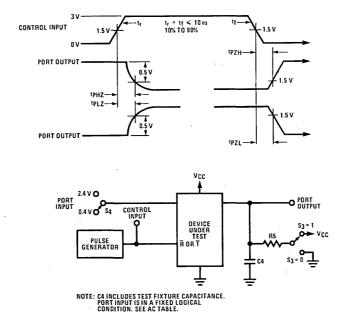


Figure B. Propagation Delay to/from TRI-STATE from  $\overline{R}$  to A Port and  $\overline{T}$  to B Port

# National Semiconductor

## **Bus Transceivers**

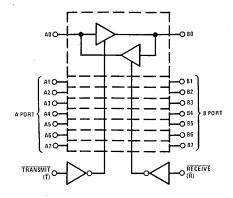
## DP7308/DP8308 8-Bit TRI-STATE® Bidirectional Transceiver (Non-Inverting)

#### **Features**

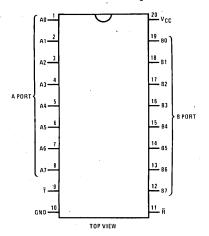
- 8-bit bidirectional data flow reduces system package count
- Bidirectional TRI-STATE inputs/outputs interface with bus oriented systems
- PNP inputs reduce input loading
- Output high voltage interfaces with TTL, MOS, and CMOS
- 48 mA/300 pF bus drive capability

- Pinouts simplify system interconnections
- Independent T and R controls for versatility
- Compact 20-pin dual-in-line package
- Bus port glitch free power up/down

## **Logic and Connection Diagrams**



#### Dual-In-Line Package



Order Number DP7308J, DP8308J or DP8308N See NS Package J20A or N20A

## Logic Table

CONTRO	OL INPUTS	RESULTING CONDITIONS				
Transmit	Receive	A Port	B Port			
1	0	OUT	1N			
0	1	IN .	OUT			
. 1	. 1	TRI-STATE	TRI-STATE			
0	0 .	Both Active*				

<sup>\*</sup>This is not an intended logic condition and may cause oscillations.

ote 1)	Recommended C	perating	g Condi	tions
7 V 5.5 V	Supply Voltage (VCC)	Min	Max	Units
	DP7308 DP8308	4.5 4.75	5.5 5.25	V V
1667 mW	Temperature $(T_A)$			
1832 mW	DP7308	-55	125	°C
300°C	DP8308	0	70	°C
	5.5 V 5.5 V to +150° C 1667 mW 1832 mW	7 V 5.5 V 5.5 V Supply Voltage (V <sub>CC</sub> ) 5.5 V DP7308 DP8308  1667 mW Temperature (T <sub>A</sub> ) 1832 mW DP7308	7 V Min 5.5 V Supply Voltage (V <sub>CC</sub> ) 5.5 V DP7308 4.5 to +150°C DP8308 4.75  1667 mW Temperature (T <sub>A</sub> ) 1832 mW DP7308 -55	7V Min Max 5.5V Supply Voltage (VCC) 5.5V DP7308 4.5 5.5 DP8308 4.75 5.25  1667 mW Temperature (TA) 1832 mW DP7308 –55 125

## DC Electrical Characteristics (Notes 2 and 3)

٠	Parameter	Co	nditions		Min	Тур	Max	Units
A Port (A	.0-A7)							
VIH	Logical "1" Input Voltage	$\overline{T} = V_{IL}, \overline{R} = 2.0V$		`	2.0			٧
VIL	Logical "0" Input Voltage	T = V <sub>IL</sub> , R = 2.0V	. [	P8308			0.8	V
				P7308			0.7	٧
VoH	Logical "1" Output Voltage	$\overline{T}$ = 2.0V, $\overline{R}$ = V <sub>IL</sub>	. 10	OH = -0.4 mA	V <sub>CC</sub> -1.15	V <sub>CC</sub> -0.7		v
			Ĩ	OH = -3 mA	2.7	3.95		٧
VOL	Logical "0" Output Voltage		I <sub>OL</sub> = 1	6 mA (8308)		0.35	0.5	V
		R = VIL	1 <sub>OL</sub> = 8	mA (both)		0.3	0.4	٧
los	Output Short Circuit Current	$\overline{T}$ = 2.0V, $\overline{R}$ = V <sub>1L</sub> , V <sub>O</sub> = 0V, V <sub>CC</sub> = max, Note 4		-10	-38	-75	mA	
ΊΗ	Logical "1" Input Current	T = V <sub>IL</sub> , R = 2.0V	, V <sub>IH</sub> = 2	2.7V		0.1	80	μΑ
11	Input Current at Maximum Input Voltage	$\overline{R} = \overline{T} = 2.0 \text{ V}, \text{ V}_{CC} = \text{max}, \text{ V}_{IH} = 5.25 \text{ V}$					1	mA
IIL "	Logical "0" Input Current	T = V <sub>IL</sub> , R = 2.0V	, V <sub>IN</sub> = 0	).4V		-70	-200	μΑ
VCLAMP	Input Clamp Voltage	$\overline{T} = \overline{R} = 2.0 \text{ V}, I_{1N}$	$\overline{T} = \overline{R} = 2.0 \text{ V}, I_{1N} = -12 \text{ mA}$			-0.7	-1.5	٧
IOD Output/Input		T = R = 2.0 V		'IN = 0.4 V			-200	μΑ
	TRI-STATE Current		V	'IN = 4.0 V			80	μΑ
B Port (B	0-B7)		•					
VIH	Logical "1" Input Voltage	T = 2.0V, R = VIL			2.0			٧
VIL	Logical "0" Input Voltage	T = 2.0V, R = VIL	. [	P8308			0.8	٧
				P7308			0.7	٧
Vон	Logical "1" Output Voltage	$\overline{T} = V_{IL}, \overline{R} = 2.0V$	I	OH = -0.4 mA	V <sub>CC</sub> -1.15	V <sub>CC</sub> -0.8		٧
		-	10	OH = -5 mA	2.7	3.9		٧
			10	OH = -10 mA	2.4	3.6		٧
VOL	Logical "0" Output Voltage	$\overline{T} = V_{IL}$ , $\overline{R} = 2.0V$	I	OL = 20 mA		0.3	0.4	٧
			10	OL = 48 mA		0.4	0.5	٧
los	Output Short Circuit Current	$\overline{T} = V_{IL}$ , $\overline{R} = 2.0V$ , $V_{CC} = max$ , Note	_	V,	-25	-50	-150	mA
ΊΗ	Logical "1" Input Current	$\overline{T} = 2.0V, \overline{R} = V_{IL}$	, V <sub>IH</sub> = 2	2.7V		0.1	80	μΑ
t <sub>L</sub>	Input Current at Maximum Input Voltage	$\overline{T} = \overline{R} = 2.0 \text{ V, V}_{CC}$	c = max,	V <sub>IH</sub> = 5.25V			1	mA
IIL	Logical "0" Input Current	T = 2.0V, R = VIL	$\sqrt{V_{IN}} = 0$	).4V		-70	-200	μΑ
VCLAMP	Input Clamp Voltage	$\overline{T} = \overline{R} = 2.0 \text{ V}, I_{1N}$	= -12 m/	<del>\</del> \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \		-0.7	-1.5	٧
lop	Output/Input	$\overline{T} = \overline{R} = 2.0 V$		'IN = 0.4 V			-200	μΑ
	TRI-STATE Current		Γv	'IN = 4.0 V			+200	μΑ

## DC Electrical Characteristics (cont'd.) (Notes 2 and 3)

	Parameter	Cor	nditions	Min	Тур	Max	Units
Contro	I Inputs T, R						
VIH	Logical "1" Input Voltage			2.0			٧
VIL	Logical "0" Input Voltage		DP8308			0.8	٧
	,		DP7308			0.7	·V
ПН	Logical "1" Input Current	V <sub>IH</sub> = 2.7 V			0.5	20	μΑ
4	Maximum Input Current	VCC = max, V <sub>IH</sub> = 5.25 V				1.0	mA
HL	Logical "0" Input Current	VIL = 0.4 V	R		-0.1	-0.25	mA
			Ŧ		-0.25	-0.5	mA
VCLA	MP Input Clamp Voltage	I <sub>IN</sub> = -12 mA			-0.8	-1.5	V
Power	Supply Current						
ICC	Power Supply Current	T = R = 2.0V, VII	N = 0.4 V, V <sub>CC</sub> = max		70	100	mA
			R = 2V, V <sub>CC</sub> = max		90	140	mA

## AC Electrical Characteristics $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$

	Parameter	Conditions	Min	Тур	Max	Units
A Port Da	ata/Mode Specifications					
tPDHLA	Propagation Delay to a Logical "0" from B Port to A Port	$\overline{T}$ = 2.4 V, $\overline{R}$ = 0.4 V (figure A) R1 = 1k, R2 = 5k, C1 = 30 pF		14	18	ns
<sup>t</sup> PD <b>L</b> HA	Propagation Delay to a Logical "1" from B Port to A Port	$\overrightarrow{T}$ = 2.4 V, $\overrightarrow{R}$ = 0.4 V (figure A) R1 = 1k, R2 = 5k, C1 = 30 pF		13	18	ns
tPLZA	Propagation Delay from a Logical "0" to TRI-STATE from $\overline{R}$ to A Port	B0 to B7 = 0.4 V, T = 2.4 V (figure B) S3 = 1, R5 = 1k, C4 = 15 pF		11	15	ns
<sup>t</sup> PHZA	Propagation Delay from a Logical "1" to TRI-STATE from $\overline{R}$ to A Port	B0 to B7 = 2.4 V, T = 2.4 V (figure B) S3 = 0, R5 = 1k, C4 = 15 pF		8	15	ns
tPZLA	Propagation Delay from TRI-STATE to a Logical "0" from $\overline{R}$ to A Port	B0 to B7 = 0.4 V, T = 2.4 V (figure B) S3 = 1, R5 = 1k, C4 = 30 pF		24	35	ns
<sup>t</sup> PZHA	Propagation Delay from TRI-STATE to a Logical "1" from $\overline{R}$ to A Port	B0 to B7 = 2.4 V, T = 2.4 V (figure B) S3 = 0, R5 = 5k, C4 = 30 pF		21	30	ņs
B Port Da	ata/Mode Specifications		<u> </u>			
<sup>t</sup> PDHLB	Propagation Delay to a Logical "0" from A Port to B Port	$\overline{T}$ = 0.4 V, $\overline{R}$ = 2.4 V (figure A) R1 = 100 $\Omega$ , R2 = 1k, C1 = 300 pF R1 = 667 $\Omega$ , R2 = 5k, C1 = 45 pF		18 11	23 18	ns ns
<sup>t</sup> PDLHB	Propagation Delay to a Logical "1" from A Port to B Port	$\overrightarrow{T}$ = 0.4 V, $\overrightarrow{R}$ = 2.4 V (figure A) R1 = 100 $\Omega$ , R2 = 1k, C1 = 300 pF R1 = 667 $\Omega$ , R2 = 5k, C1 = 45 pF		16 11	23 18	ns ns
tPLZB	Propagation Delay from a Logical "0" to TRI-STATE from $\overline{T}$ to B Port	A0 to A7 = 0.4 V, $\overline{R}$ = 2.4 V (figure B) S3 = 1, R5 = 1k, C4 = 15 pF		13	18	ns
<sup>t</sup> PHZB	Propagation Delay from a Logical "1" to TRI-STATE from $\overline{T}$ to B Port	A0 to A7 = 2.4 V, $\overline{R}$ = 2.4 V (figure B) S3 = 0, R5 = 1k, C4 = 15 pF		8	15	ns
<sup>t</sup> PZLB	Propagation Delay from TRI-STATE to a Logical "0" from $\overline{T}$ to B Port	A0 to A7 = 0.4 V, $\overline{R}$ = 2.4 V (figure B) S3 = 1, R5 = 100 $\Omega$ , C4 = 300 pF S3 = 1, R5 = 667 $\Omega$ , C4 = 45 pF		25 17	35 25	ns ns
<sup>t</sup> PZHB	Propagation Delay from TRI-STATE to a Logical "1" from $\overline{T}$ to B Port	A0 to A7 = 2.4 V, $\overline{R}$ = 2.4 V (figure B) S3 = 0, R5 = 1k, C4 = 300 pF S3 = 0, R5 = 5k, C4 = 45 pF		24 17	35 25	ns ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the supply and temperature range listed in the table of Recommended Operating Conditions. All typical values given are for V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C.

Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise specified.

Note 4: Only one output at a time should be shorted.

### Switching Time Waveforms and AC Test Circuits

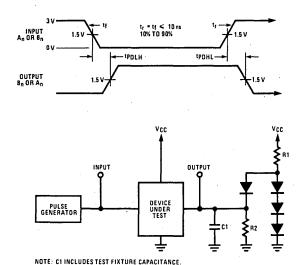


FIGURE A. Propagation Delay from A port to B port or from B port to A port

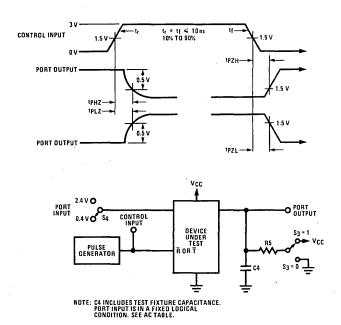


Figure B. Propagation Delay to/from TRI-STATE from  $\overline{R}$  to A Port and  $\overline{T}$  to B Port



# **Bus Transceivers**

# DS26S10, DS26S11 Quad Bus Transceivers

# **General Description**

The DS26S10 and DS26S11 are quad Bus Transceivers consisting of 4 high speed bus drivers with open-collector outputs capable of sinking 100 mA at 0.8V and 4 high speed bus receivers. Each driver output is connected internally to the high speed bus receiver in addition to being connected to the package pin. The receiver has a Schottky TTL output capable of driving 10 Schottky TTL unit loads.

An active low enable gate controls the 4 drivers so that outputs of different device drivers can be connected together for party-line operation.

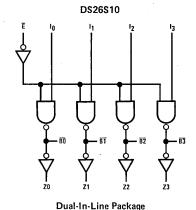
The bus output high-drive capability in the low state allows party-line operation with a line impedance as low as  $100\Omega$ . The line can be terminated at both ends, and still give considerable noise margin at the receiver. The receiver typical switching point is 2V.

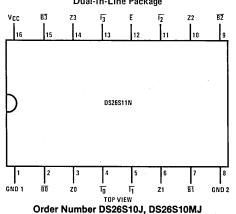
The DS26S10 and DS26S11 feature advanced Schottky processing to minimize propagation delay. The device package also has 2 ground pins to improve ground current handling and allow close decoupling between VCC and ground at the package. Both GND 1 and GND 2 should be tied to the ground bus external to the device package.

### **Features**

- Input to bus is inverting on DS26S10
- Input to bus is non-inverting on DS26S11
- Quad high speed open-collector bus transceivers
- Driver outputs can sink 100 mA at 0.8V maximum
- Advanced Schottky processing
- PNP inputs to reduce input loading

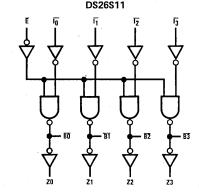
### **Logic and Connection Diagrams**

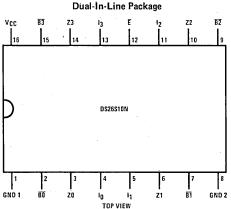




or DS26S10N

See NS Package J16A or N16A





# **Absolute Maximum Ratings**

Storage Temperature	-65°C to +150°C
Temperature (Ambient) Under Bias	-55°C to +125°C
Supply Voltage to Ground Potential	-0.5V to +7V
DC Voltage Applied to Outputs for	-0.5V to +V <sub>CC</sub> Max
High Output State	
DC Input Voltage	-0.5V to +5.5V
Output Current, Into Bus	200 mA
Output Current, Into Outputs (Except Bus)	30 mA
DC Input Current	-30 mA to +5 mA

DC Input Current -30 mA to +5 mA
Maximum Power Dissipation\* at 25°C
Cavity Package 1433 mW
Molded Package 1362 mW

\*Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.9 mW/°C above 25°C.

# **Operating Conditions**

	MIN	MAX	UNITS
Supply Voltage (VCC)			
DS26S10XC, DS26S11XC	4.75	5.25	V
DS26S10XM, DS26S11XM	4.5	5.5	V
Temperature (TA)			
DS26S10XC, DS26S11XC	0	+70	°C
DS26S10XM, DS26S11XM	-55	+125	°C

### Electrical Characteristics (Unless otherwise noted)

PARAMETER		CONDITION (Note 1)	CONDITIONS (Note 1)			MAX	UNITS	
Voн	Output High Voltage	V <sub>CC</sub> = Min, I <sub>OH</sub> = -1 mA,	Military	2.5	3.4		V	
	(Receiver Outputs)	VIN = VIL or VIH	Commercial	2.7	3.4		٧	
VOL	Output Low Voltage (Receiver Outputs)	V <sub>CC</sub> = Min, I <sub>OL</sub> = 20 mA, V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub>				0.5	V	
VIH	Input High Level (Except Bus)	Guaranteed Input Logical Hig All Inputs	Guaranteed Input Logical High for All Inputs				٧	
VIL	Input Low Level (Except Bus)	Guaranteed Input Logical Lov All Inputs			0.8	٧		
VI	Input Clamp Voltage (Except Bus)	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18 mA			-1.2	V		
l <sub>IL</sub>	Input Low Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V	Enable			-0.36	mA	
	(Except Bus)	VCC = Max, VIN = 0.4V	Data			-0.54	mA	
ЧН	Input High Current	V M V 2.7V	Enable			20	μΑ	
	(Except Bus)	V <sub>CC</sub> ≈ Max, V <sub>IN</sub> = 2.7V	Data			30	μΑ	
lį	Input High Current (Except Bus)	V <sub>CC</sub> = Max, V <sub>IN</sub> = 5.5V				100	μΑ	
Isc	Output Short-Circuit Current	N - May (Nata 2)	Military	-20		-55	mA	
	(Except Bus)	V <sub>CC</sub> = Max, (Note 3)	Commercial	-18		-60	mA	
ICCL	Power Supply Current	Von = May Enable = Gnd	DS26S10		45	70	mA	
	(All Bus Outputs Low)	V <sub>CC</sub> = Max, Enable = Gnd	DS26S11			80	mA	

# **Bus Input/Output Characteristics**

PARAMETER		PARAMETER CONDITIONS (Note 1)			MIN	TYP (Note 2)	MAX	UNITS
VOL	Output Low Voltage			IOL = 40 mA		0.33	0.5	
			Military	IOL = 70 mA	1	0.42	0.7	
		V <sub>CC</sub> = Min		IOL = 100 mA		0.51	0.8	V
				I <sub>OL</sub> = 40 mA		0.33	0.5	•
			Commercial	I <sub>OL</sub> = 70 mA		0.42	0.7	
				I <sub>OL</sub> = 100 mA		0.51	0.8	
10	Bus Leakage Current			V <sub>O</sub> = 0.8V			-50	
		V <sub>CC</sub> = Max	Military	V <sub>O</sub> = 4.5V			200	μΑ
			Commercial	V <sub>O</sub> = 4.5V			100	
IOFF	Bus Leakage Current (Power OFF)	V <sub>O</sub> = 4.5V					100	μΑ
VTH	Receiver Input High Threshold	Bus Enable =	2.4V,	Military	2.4	2.0		V
		V <sub>CC</sub> = Max		· Commercial	2.25	2.0		V
VTL	Receiver Input Low Threshold	Bus Enable =	2.4V,	Military		2.0	1.6	V
		V <sub>CC</sub> = Min		Commercial		2.0	1.75	v

Note 1: For conditions shown as min or max, use the appropriate value specified under Electrical Characteristics for the applicable device type.

Note 2: Typical limits are at  $V_{CC} = 5V$ ,  $25^{\circ}C$  ambient and maximum loading.

Note 3: Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.

# Switching Characteristics (TA = 25°C, VCC = 5V)

PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS
tPLH	Data Input to Bus	\	DCCCC10		10	15	ns
tPHL	Data Input to Bus		DS26S10	,	10	15	ns
tPLH	Data Input to Bus		DS26S11		12	19	ns
<sup>t</sup> PHL	Data Input to Bus		D320311		12	19	ns
†PLH	Enable Input to Bus	$R_B = 50\Omega$ , $C_B = 50 pF$ (Note 1)	DS26S10		14	18	ns
tPHL	Enable Input to Bus		D526510		13	18	ns
tPLH	Enable Input to Bus		DS26S11		15	20	ns
tPHL.	Enable Input to Bus		D320311		14	20	ns
tPLH	Bus to Receiver Out	$R_B = 50\Omega$ , $R_L = 280\Omega$ , $C_B = 50 p$	F (Note 1),		10	15	ns
<sup>t</sup> PHL	Bus to Receiver Out	CL = 15 pF			10	15	ns
tŗ	Bus	Pn = 500, Cn = 50 n5 (Note 1)		4.0	10		ns
tf	Bus	$R_B = 50\Omega$ , $C_B = 50 pF$ (Note 1)	2.0	4.0		ns	

Note 1: Includes probe and jig capacitance

# **Truth Tables**

DS26S10

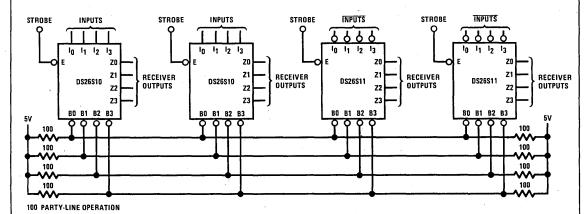
OUTPUTS

INP	INPUTS  E I L L		OUTPUTS			
Ē	1	B	Z			
L	L	Н	L			
L	Н	· L	Н			
н	×	Y	Ÿ			

### DS26S11

INP	UTS	OUTPUTS		
Ē	Ī	B	Z	
L	L	L	Н	
L.	н	н	L	
Н	Х	Y	Ÿ	

# Typical Application



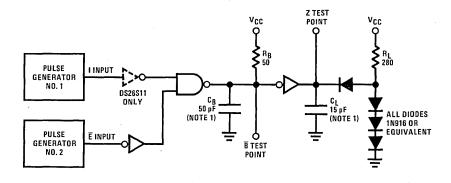
H = High voltage level

L = Low voltage level

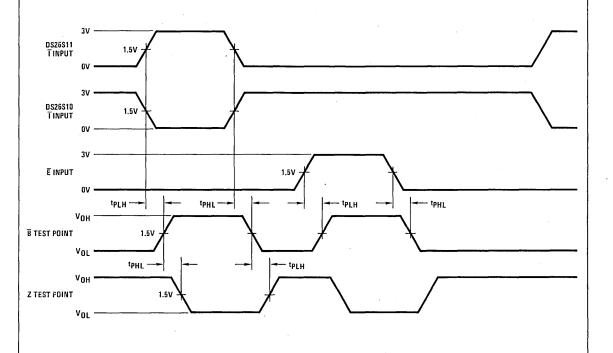
X = Don't care

Y = Voltage level of bus (assumes control by another bus transceiver)

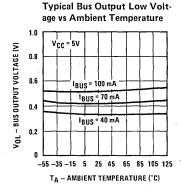
# **AC Test Circuit and Switching Time Waveforms**

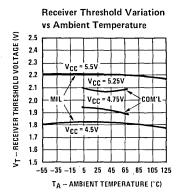


Note 1: Includes probe and jig capacitance.

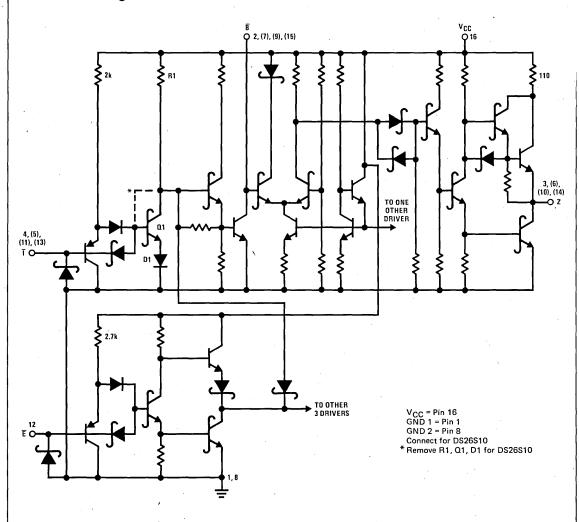


# **Typical Performance Characteristics**





# **Schematic Diagram**



# DS3662 Quad High Speed Trapezoidal<sup>™</sup> Bus Transceiver

# **General Description**

The DS3662 is a quad high speed Schottky bus transceiver intended for use with terminated 120 $\Omega$  impedance lines. It is specifically designed to reduce noise in unbalanced transmission systems. The open collector drivers generate precise trapezoidal waveforms with rise and fall times of 15 ns (typical), which are relatively independent of capacitive loading conditions on the outputs. This reduces noise coupling to the adjacent lines without any appreciable impact on the maximum data rate obtainable with high speed bus transceivers. In addition, the receivers use a low pass filter in conjunction with a high speed comparator, to further enhance the noise immunity. Tightly controlled threshold levels on the receiver provide equal rejection to both negative and positive going noise pulses on the bus.

The external termination is intended to be a  $180\Omega$  resistor from the bus to 5V logic supply, together with a  $390\Omega$  resistor from the bus to ground. The bus can be terminated at one or both ends. A two input NOR gate is provided to disable all drivers in a package simultaneously.

### **Features**

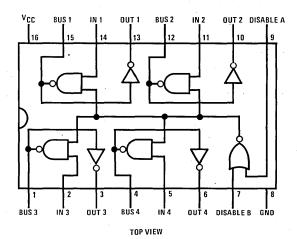
- Pin to pin functional replacement for DS8641
- Guaranteed AC specifications on noise immunity and propagation delay over the specified temperature and supply voltage range

**Bus Transceivers** 

- Temperature insensitive receiver thresholds track bus logic level
- Trapezoidal bus waveforms reduce noise coupling to adjacent lines
- Precision receiver thresholds provide maximum noise immunity and symmetrical response to positive and negative going pulses
- Open collector driver output allows wire-OR connection
- High speed Schottky technology
- 15  $\mu$ A typical bus termination current with normal  $V_{CC}$  or with  $V_{CC}$  = 0V
- Glitch free power up/down protection on the driver output
- TTL compatible driver and disable inputs, and receiver outputs

# **Block and Connection Diagram**

### **Dual-In-Line Package**



Order Number DS3662J or DS3662N See NS Package J16A or N16A

Trapezoidal TM is a trademark of National Semiconductor

# Absolute Maximum Ratings (Note 1)

Supply Voltage 7V
Input and Output Voltage 5.5V
Storage Temperature Range -65°C to 150°C
Maximum Power Dissipation\* at 25°C
Cavity Package 1509 mW
Molded Package 1476 mW

# **Recommended Operating Conditions**

	•	•	
	Min	Max	Units
Supply Voltage (V <sub>CC</sub> )	4.75	5.25	v
Temperature Range (TA	) 0	70	°C

<sup>\*</sup>Derate cavity package 10.1 mW/°C above 25°C; derate molded package 11.8 mW/°C above 25°C.

### Electrical Characteristics (Notes 2 and 3)

Lead Temperature (Soldering, 10 seconds)

	Parameter	Conditions	Min	Тур	Max	Units		
DRIVE	DRIVER AND DISABLE INPUTS							
V <sub>IH</sub>	Logical "1" Input Voltage		2.0		7.	٧		
V <sub>IL</sub>	Logical "0" Input Voltage				0.8	٧		
1	Logical "1" Input Current	V <sub>IN</sub> = 5.5V			1	mA		
I <sub>IH</sub>	Logical "1" Input Current	V <sub>IN</sub> = 2.4V			40	μΑ		
I <sub>IL</sub>	Logical "0" Input Current	V <sub>IN</sub> = 0.4V		-1	- 1.6	mA		
V <sub>CL</sub>	Input Diode Clamp Voltage	I <sub>CLAMP</sub> = -12 mA		- 0.8	- 1.5	٧		
DRIVE	R OUTPUT/RECEIVER INPUT							
V <sub>OLB</sub>	Low Level Bus Voltage	$V_{DIS} = 0.8V$ , $V_{IN} = 2V$ , $I_{BUS} = 100 \text{ mA}$		0.6	0.9	٧		
I <sub>IHB</sub>	Maximum Bus Current	$V_{IN} = 0.8V$ , $V_{BUS} = 4V$ , $V_{CC} = 5.25V$		10	100	μΑ		
I <sub>ILB</sub>	Maximum Bus Current	$V_{IN} = 0.8V$ , $V_{BUS} = 4V$ , $V_{CC} = 0V$			100	μΑ		
V <sub>IH</sub>	High Level Receiver Threshold	V <sub>IN</sub> = 0.8V, I <sub>OL</sub> = 16 mA	1.90	1.70		٧		
V <sub>IL</sub>	Low Level Receiver Threshold	$V_{1N} = 0.8V$ , $I_{OH} = -400 \mu\text{A}$		1.70	1.50	٧		
RECEI	VER OUTPUT							
V <sub>OH</sub>	Logical "1" Output Voltage	$V_{IN} = 0.8V$ , $V_{BUS} = 0.5V$ , $I_{OH} = -400 \mu A$	2.4	3.2		٧		
V <sub>OL</sub>	Logical "0" Output Voltage	$V_{IN} = 0.8V$ , $V_{BUS} = 4V$ , $I_{OL} = 16 \text{ mA}$		0.35	0.5	٧		
los	Output Short Circuit Current	$V_{DIS} = 0.8V$ , $V_{IN} = 0.8V$ , $V_{BUS} = 0.5V$ , $V_{OS} = 0V$ , $V_{CC} = 5.25V$ , (Note 4)	- 40	-70	-100	mA		
Icc	Supply Current \	$V_{DIS} = 0V$ , $V_{IN} = 2V$		50	90	mA		

300°C

# Switching Characteristics (Notes 2 and 3)

	Parameter	Conditions	Min	Тур	Max	Units
PROPAGA	TION DELAYS					
t <sub>PLHD</sub>	Disable to Bus "1"	Fig 4		25	35	ns
t <sub>PHLĎ</sub>	Disable to Bus "0"	Figure 1		25	35	ns
t <sub>PLHB</sub>	Driver Input to Bus "1"	<b>5</b> : <b>2</b>		20	30	ns
t <sub>PHLB</sub>	Driver Input to Bus "0"	Figure 2		20	30	ns
t <sub>PLHR</sub>	Bus to Logical "1" Receiver Output			25	40	ns
t <sub>PHLR</sub>	Bus to Logical "0" Receiver Output	Figure 3		25	40	ns
NOISE IMM	MUNITY					
t <sub>rB</sub> , t <sub>fB</sub>	Rise and Fall Times (10%-90%) of the Driver Output	Figure 2	10	15	20	ns
t <sub>nR</sub>	Receiver Noise Rejection Pulse Width	No Response at Receiver Output as per Figure 4		20	10	ns

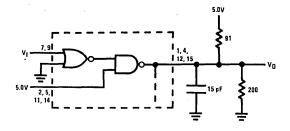
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" and "Recommended Operating Conditions" provide conditions for actual device operation.

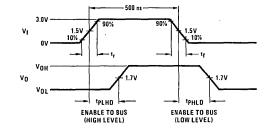
Note 2: Unless otherwise specified min/max limits apply across the supply and temperature range listed in the table of "Recommended Operating Conditions". All typical values are for T<sub>A</sub> = 25°C and V<sub>CC</sub> = 5V.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

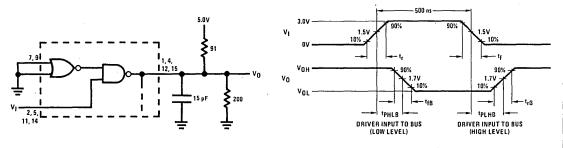
# **AC Test Circuits and Switching Waveforms**





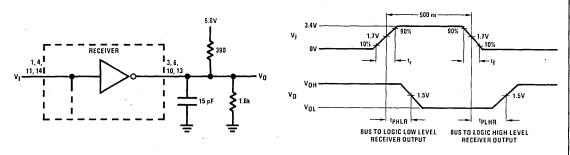
Note.  $t_f = t_f = 2.5$  ns. Pulse width = 500 ns measured between 1.5V levels. f = 1 MHz.

FIGURE 1. Disable Delays



Note.  $t_f = t_f = 2.5$  ns. Pulse width = 500 ns measured between 1.5V levels. f = 1 MHz.

FIGURE 2. Driver Propagation Delays



Note.  $t_f = t_f = 15$  ns. Pulse width = 500 ns measured between 1.7V levels. f = 1 MHz.

FIGURE 3. Receiver Propagation Delays

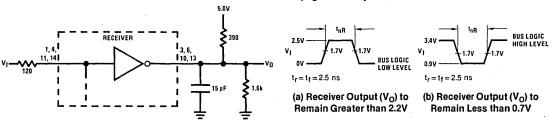
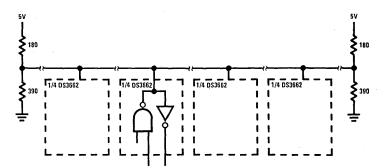


FIGURE 4. Receiver Noise Immunity: "No Response at Output" input Waveforms

# Typical Application

# 120Ω Unified Data Bus



# DS3662 — The Bus Optimizer National Semiconductor

National Semiconductor Application Note 259 R.V. Balakrishnan April 1981



### I. Introduction

A single ended Bus is an unbalanced Data Transmission medium, which is timeshared by several system elements. Like any unbalanced system, it is highly susceptible to common-mode noise, such as ground noise and crosstalk. In general, the latter determines the maximum physical length of the Bus that can be incorporated with acceptable reliability. Crosstalk is a major problem in high speed computer Buses which employ Schottky Transceivers for increased data rate capability. It is therefore highly desirable to minimize crosstalk noise in Bus circuits to allow for longer Buses and to provide higher system reliability.

This article describes the operation of the DS3662 Quad High Speed Trapezoidal Bus Tranceiver, which has been specially designed to minimize crosstalk problems. The Driver generates precise Trapezoidal waveforms that reduce noise coupling to adjacent Bus channels. The Receiver uses a low pass filter, whose time constant is matched to the Driver slew rate to provide maximum noise rejection with acceptable signal delay characteristics. Precision high speed circuitry optimizes noise immunity without sacrificing the high data rate capability of Schottky Tranceivers.

### II. The Problem

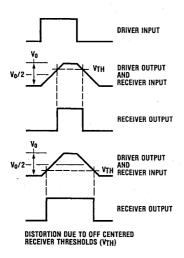
Conventional Bus Drivers are designed to provide high output currents for charging and discharging relatively large Bus capacitances quickly. These high speed transitions are characterized by peak slew rates of up to 5 volts/ns around the mid-region of the transition. This can cause considerable noise coupling to adjacent lines, commonly referred to as crosstalk. Crosstalk also

includes noise induced by sources external to the Bus. Additional noise may be generated due to reflections at imperfect terminations.

Bus Receivers are designed to respond to high speed transitions and to provide low propagation delays. Unfortunately, their fast response results in high noise sensitivity. The combined effect of the noise on the Bus and the sensitivity of the Receiver to the noise severely limits the Bus performance.

### III. The Solution

The above situation can be considerably improved by employing noise reduction techniques in both the Driver and the Receiver circuits. Slew rate control can be used in the Driver to reduce crosstalk, and Receiver noise sensitivity can be reduced by using a low pass filter at its input. These techniques are commonly used in line transmission circuits where the associated data rates in general are considerably lower. However, these techniques do present some difficulties in high speed Bus circuits. Increased rise and fall times, resulting from slew rate control, can affect data rates unless care is taken to limit the maximum rise and fall times to minimum pulse width requirements. With any appreciable slew rate control, the rise and fall times of the resulting Driver output waveform will be comparable to the pulse widths at maximum data rates. This condition dictates high fidelity of the transmitted waveform and precise Receiver thresholds at the middle of the Bus voltage swing in order to minimize pulse width distortion. Figure 1 illustrates the different sources of pulse width distortion due to the trapezoidal nature of the signal.



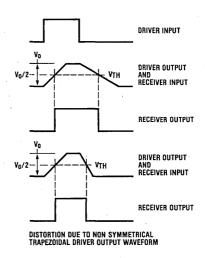


Figure 1. Pulse Width Distortion

The low pass filter in the Receiver should provide optimum noise rejection without introducing excessive delay in passing the signal waveform. In addition, the Receiver should have a symmetrical response to positive and negative going transitions in order to maintain a low level of pulse width distortion, as well as equal noise rejection to positive and negative going noise pulses. The response of an ideal low pass filter to signal and noise pulses is shown in Figure 2.

The DS3662 overcomes these and other problems by using high speed linear circuitry with on-chip capacitors for controlling slew rate and low pass filtering. The Driver is of open collector type intended for use with terminated 120 ohm Buses. The external termination consists of a 180 ohm resistor from the Bus to +5 volts logic supply with a 390 ohm resistor from the Bus to ground. Such a termination results in a Bus logic high level of 3.4 volts with  $V_{\rm CC}$  at 5 volts (see Figure~2). The Bus can be terminated at one or both ends as shown in Figure~3.

### IV. The Driver

Using a Miller Integrator circuit, the Driver generates a linearly rising and falling waveform with a constant slew rate of 0.2 volts/ns (typical) during the entire period of transition. This corresponds to typical rise and fall times of 15 ns. Figure 4 compares the output waveform of a typical Schottky Driver and the DS3662 under different capacitive loads. It should be noted that even under heavy loading, the regular Drivers have peak slew rates that are considerably higher than the average. In contrast, the trapezoidal waveform provides considerably lower slew rate with slightly higher rise and fall times. Such an increase in rise and fall time has very little effect on data rates. In fact, the high fidelity of the transmitted waveform allows pulse widths as low as 20 ns to be transmitted on the Bus, as shown in Figure 5.

The block diagram of the Driver is shown in Figures 6 and 7. When a high to low transition is applied to the input, switch 'S' opens and node 'A' is pulled low by the current source 'I'. This switches the amplifier output to a high state. The slew rate of the output transition is limited by the charging current through the capacitor, a constant value equal to I/C volts/sec.

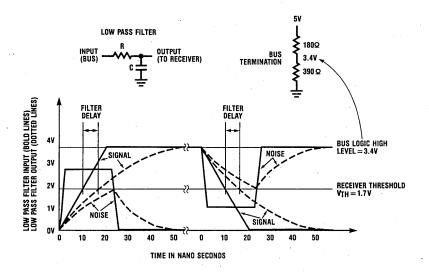


Figure 2. Ideal Receiver Low Pass Filter Response

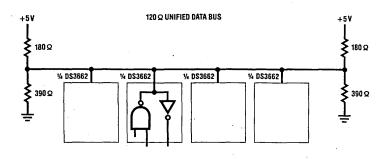


Figure 3. Bus Termination

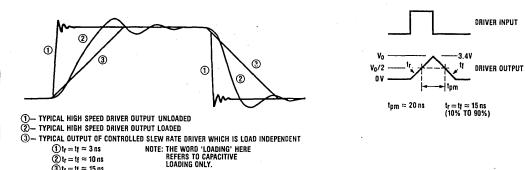


Figure 4. Waveform Comparison

② $t_f = t_f \approx 10 \text{ ns}$  $3t_r = t_f \approx 15 \, \text{ns}$ 

Figure 5. Minimum Pulse Width Driver Output

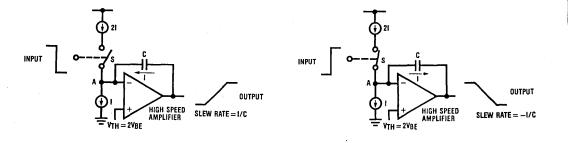


Figure 6. Driver

Figure 7. Driver

Likewise, when a low to high transition is applied to the input, switch 'S' closes and node 'A' is pulled up by the '2!' current source, switching the amplifier output to a low state. The capacitor now has an equal but opposite charging current which once again limits the slew rate o -I/C volts/sec. The inherent tracking ability of I.C. current sources provide equal rise and fall times resulting in a symmetrical output waveform.

The on-chip capacitors are fabricated using back to back junction diodes. The use of junction capacitors reduces die area and the back to back connection allows operation with either polarity. The capacitor terminal, connected to the amplifier input, remains at  $V_{th} \simeq 1.6$  volts during the output transition. This voltage, being close to the middle of the output swing, reduces the effect of the capacitor voltage sensitivity on the output waveshape.

### V. The Receiver

The Receiver consists of a low pass filter followed by a high speed comparator with a typical threshold of 1.7 volts (see *Figure 8*). This threshold value corresponds to the mid-point voltage of the 0 to 3.4 volt Bus swing. It is derived from a potential divider allowing the Bus logic levels to track with  $V_{\rm CC}$  variations. If the low pass filter capacitor is voltage insensitive, this circuit will provide equal propagation delay for positive and negative going signal transitions on the Bus. In addition, it will also provide equal noise rejection to a positive and negative

going pulse (see *Figure 2*). However, the junction capacitors, being voltage sensitive, will exhibit non-symmetrical response in the above circuit. This problem is overcome in the DS3662 Receiver by using a back to back junction capacitor with the ground end biased at 1.7 volts (see *Figure 9*). Although the capacitor still varies with the voltage at node 'A', the variation is symmetrical about 1.7 volts (the middle of the Bus swing) and therefore will provide an identical response to transitions of either polarity.

### VI. Transceiver Performance

The characteristics of the trapezoidal Transceiver are fully detailed in the device data sheet. Some of the more important specifications are discussed below. Both AC and DC specifications are guaranteed over a 0-70°C temperature range and a supply range of 4.75-5.25 volts.

The Driver typically has a propagation delay of 15ns with a maximum of 30ns. The Receiver propagation delays are specified at 25ns typical and 40ns maximum. The Driver output rise and fall times are guaranteed to be within 10 to 20ns with a typical of 15ns. The noise immunity of the Receiver is specified in terms of the width of a 2.5 volt pulse that is guaranteed to be rejected by the Receiver (see *Figure 10*). The Receiver typically rejects a 20ns pulse going positive from ground level or going negative from a 3.4 volt logic 1 level. Worst case rejection is specified at 10ns.

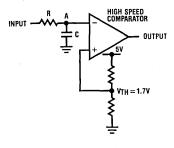


Figure 8. Receiver

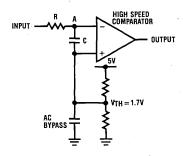
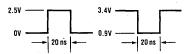


Figure 9. Receiver



REJECTS POSITIVE OR NEGATIVE GOING NOISE PULSES OF PULSE WIDTHS UP TO 20 ns TYPICAL. DETECTS AND PROPAGATES TRAPEZOIDAL SIGNAL PULSES IN 20 ns TYPICAL.

Figure 10. Receiver Noise Immunity

The AC response of the DS3662 Driver and Receiver are depicted in *Figures 11* and *12* respectively. *Figure 11* shows the typical Driver output waveform as compared to a standard high speed Transceiver output. Oscillograms in *Figure 12* demonstrate the ability of the Receiver to distinguish the trapezoidal signal from the noise. Here the Receiver rejects a noise pulse of 19ns width, while accepting a narrower signal pulse (= 16 ns) of the same amplitude (The signal is triangular since the pulse width is smaller than the rise and fall time of the Trapezoidal Driver output).

The performance of the Transceiver under actual operating condition is demonstrated in Figures 13 through 15. Oscillograms in Figure 13 clearly show the capability of the DS3662 in real life situations. Here it is compared with the DS8834 under identical conditions. The Transceivers drive a minicomputer Bus (flat ribbon cable) 100 feet long, terminated at the far end with taps at various lengths for connecting to the Receiver input. The cable is randomly folded to generate crosstalk between the various parts. In addition a noise pulse is induced on the signal line by driving an adjacent line with a pulse generator. This corresponds to the second dominant pulse in the Bus waveforms at approximately 600 ns from the main signal pulse. As can be seen, the DS8834 with fast rise and fall times on the Driver output generates more crosstalk and its Receiver easily responds to this crosstalk and to the externally induced noise (even though it has hysteresis!), limiting the useful Bus length to less than 10 feet. In contrast, the DS3662's Driver generates much less crosstalk and its Receiver is immune to the induced noise even when the noise amplitude exceeds the signal amplitude as seen in the oscillogram at 50 feet. When the same experiment was repeated with the DS8641, it responded to the noise even at 10 feet as shown in *Figure 14*.

Figure 15 shows the plots of maximum data rate versus line length for the three Transceivers discussed above under two different conditions. The graph in Figure 15a is obtained with no consideration to the pulse width distortion whereas the one in Figure 15b is obtained for a maximum allowable pulse width distortion of ±10%. A square waveform is used so that the pulse width distortion criteria will apply to both positive and negative going pulses. These graphs clearly show that the DS3662 can be used at considerably higher data rates with lower distortion for longer distances than the other two Transceivers (Figure 15b) although the others have a slightly higher data rate capability at short distances with high timing distortion (Figure 15a).

### VII. Conclusion

The DS3662, with its combination of a trapezoidal Driver and a noise rejecting Receiver utilizing on chip capacitors, represents a significant improvement in high speed Bus circuits and a solution to Bus noise problems commonly encountered in Mini and Microcomputer systems.

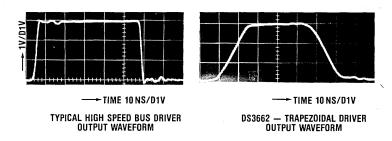


Figure 11.

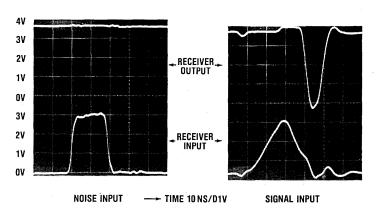
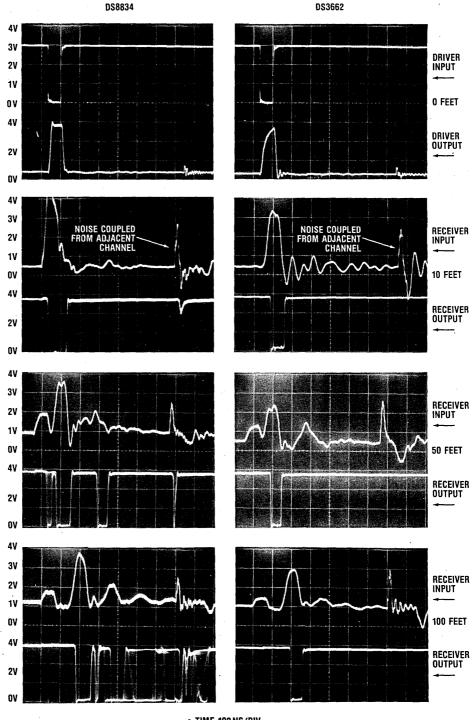


Figure 12. DS3662 Receiver Response



→ TIME 100 NS/DIV

Figure 13.

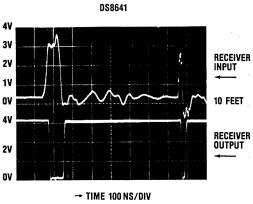
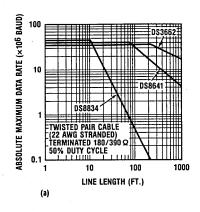


Figure 14.



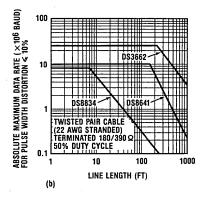


Figure 15. Data Rate vs. Line Length

# Reducing Noise on Microcomputer Buses

National Semiconductor Application Note 337 R. V. Balakrishnan May 1983



Abstract: This paper focuses on the noise components that have a significant impact on the performance of a high speed microcomputer bus. An overview of their nature is followed by ways to minimize their contribution by suitable design of the PC board backplane, the termination network and the bus transceiver. The DS3662 trapezoidal bus transceiver, which is specifically designed to minimize such noise on high speed buses, is presented along with its performance data. And to conclude, some possible new transceiver designs for further improvement of the bus performance are explored.

### INTRODUCTION

As the microcomputer bus bandwidth is extended to handle ever increasing clock rates, the noise susceptibility of a single-ended bus poses a serious threat to the overall system integrity. Thus, it is mandatory that the various noise contributions be taken into account in the design of the bus transceiver, the PC board backplane and the bus terminations to avoid intermittent or total failure of the system.

Although noise such as crosstalk and reflections are inevitable in any practical bus configuration, their impact on the system can be determined and minimized by careful design of all three components mentioned above. The combined contribution of the noise under worst-case conditions should be within the noise margin for reliable bus operation.

The design of the transceiver plays a significant role in minimizing crosstalk and reflection. The bus can be optimized for minimum noise at a given bandwidth by using a trapezoidal driver having suitable rise and fall times along with a matched low pass filtered receiver which provides a symmetrical noise margin. The DS3662 is one such transceiver, the first member in the family of trapezoidal bus transceivers available from National Semiconductor Corporation. This device represents a significant improvement in high speed bus circuit design and provides a solution to commonly encountered bus noise problems.

### THE MICROCOMPUTER BUS

A typical microcomputer bus usually consists of a printed circuit board backplane with signal and ground traces on one side and a ground plane on the other. The length ranges from a few inches to several feet with as many as 32 closely spaced (0.6" typical) card edge connectors. Each signal line interacts with the ground plane to form a transmission line with characteristic impedance 'Z' in the range of  $90\Omega-120\Omega$  typical. It is desirable to have as large a 'Z' as possible in order to reduce the drive requirement of the bus driver and to reduce the power dissipated at the terminations. But much larger values of 'Z' translate to significantly larger physical dimensions and therefore are not very practical.

The bus appears like a transmission line to any signal having a transition time ' $t_r$ ' less than the round trip delay ' $2T_L$ ' of the bus. The bus delay ' $T_L$ ' is given by:

$$T_{L} = L \sqrt{L1 C1}$$
 (1)

where L = length of the bus

L1 = distributed inductance per unit length C1 = distributed capacitance per unit length

For a typical unloaded 100 $\Omega$  microstrip line, C1  $\approx$  20 pF/ft and L1  $\approx$  0.2  $\mu$ H/ft. Therefore,  $T_L =$  2.0 ns/ft. This corresponds to approximately half the speed of light. However, the capacitive loading at each connector on the backplane increases the delay time significantly. The loaded delay time ' $T_{LL}$ ' is given by:

$$T_{LL} = T_L \sqrt{1 + (C_L/C_1)}$$
 (2)

where C<sub>L</sub> = distributed load capacitance/unit length

Given a 10 pF loading at each connector (connector + transceiver capacitance) and a 0.6" spacing between connectors,  $C_L = 200$  pF/ft and  $T_{LL} = 6.6$  ns/ft. So even a 6" long bus has a  $2T_{LL} = 6.6$  ns, which is higher than the transition time (t<sub>i</sub>) of many high speed bus drivers. When in doubt, it is always better to use the transmission line approach than the lumped circuit approach as the latter is an approximation of the former. Also, the transmission line analysis gives more pessimistic (worst-case) values of crosstalk and reflection and is, hence, safer.

#### **CROSSTALK REDUCTION**

The crosstalk is due to the distributed capacitive coupling  $C_C$  and the distributed inductive coupling  $L_C$  between two lines. When crosstalk is measured on an undriven sense line next to a driven line (both terminated at their characteristic impedances), the near end crosstalk and the far end crosstalk have quite distinct features, as shown in *Figure 1*. Their respective peak amplitudes are:

$$V_{NE} = K_{NE}(2T_L)(V_I/t_r) \quad \text{for } t_r > 2T_L$$
 (3)

$$V_{NE} = K_{NE}(V_I) \qquad \text{for } t_f < 2T_L \qquad (4)$$

$$V_{FE} = K_{FE}(L)(V_1/t_r)$$
 (5)

where  $V_1$  = signal swing on the drive line.

The coupling constants are given by the expressions:

$$K_{NE} = \frac{L (C_C Z + L_C / Z)}{4T_L}$$
 (6)

$$K_{FE} = \frac{C_C Z - L_C / Z}{2} \quad \text{ns/ft}$$
 (7)

The near end component reduces to zero at the far end and vice versa. At any point in between, the crosstalk is a fractional sum of near and far end crosstalk waveforms shown.

It should be noted from expressions 6 and 7 that the far end crosstalk can have either polarity whereas the near end crosstalk always has the same polarity as the signal causing it. In microstrip backplanes the far end crosstalk pulse is usually the opposite polarity of the original signal. Although the real world bus is far from the ideal situation depicted in *Figure 1*, several useful observations that apply to a general case can be made:

- 1. The crosstalk always scales with the signal amplitude.
- 2. Absolute crosstalk amplitude is proportional to slew rate  $V_l/t_r$ , not just  $1/t_r$ .
- 3. Far end crosstalk width is always tr.
- 4. For  $t_r < 2T_L$ , the near end crosstalk amplitude  $V_{NE}$  expressed as a fraction of signal amplitude  $V_1$  is a function of physical layout only.
- 5. The higher the value of 't<sub>r</sub>' the lower the percentage of crosstalk (relative to signal amplitude).

The corresponding design implications are:

1. The noise margin expressed as a percentage of the signal swing is what's important, not the absolute noise margin. Therefore, to improve noise immunity, the percentage noise margin has to be maximized. This is achieved by reducing the receiver threshold uncertainty region and by centering the threshold between the high and low levels.

- 2. Smaller signal amplitude with the same transition time reduces bus drive requirements without reducing noise immunity.
- 3. Far end crosstalk is eliminated if the receiver is designed to reject pulses having pulse widths less than or equal to t<sub>r</sub>.
- 4. When  $t_r < 2T_L$ , the near end crosstalk immunity for a given percentage noise margin has to be built into the backplane PC layout. Since  $(V_{NE}/V_I) = K_{NE}$  for this case,  $K_{NE}$  should be kept lower than the available worst-case noise margin.  $K_{NE}$  may be reduced by either increasing the spacing between lines or by introducing a ground line in between. The ground line, in addition to increasing the spacing between the signal lines, forces the electric field lines to converge on it, significantly reducing crosstalk.
- 5. For minimum crosstalk the rise and fall times of the signal waveform should be as large as possible consistent with the minimum pulse width requirements of the bus. A driver that automatically limits the slew rate of the transition can go a long way in reducing crosstalk.

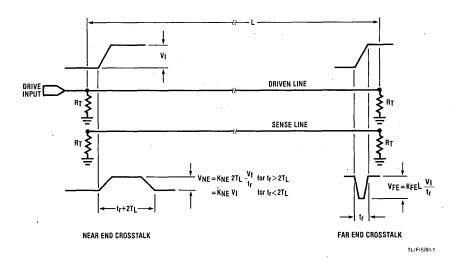


FIGURE 1. Crosstalk Under Ideal Conditions

#### CROSSTALK MEASUREMENT

When multiple lines on either side of the sense lines switch simultaneously the crosstalk is considerably larger, typically 3.5 times the single line switching case for microstrip backplanes. Also, the location of the drivers on the driven lines and the receiver on the sense line for worst-case crosstalk differs for the near end and far end cases as shown in Figures 2 and 3 for a uniformly loaded bus. But if the far end crosstalk is not of the opposite polarity, then the combined effect of far end and near end crosstalk could have a larger amplitude and pulse width at a point near the middle of the sense line in Figure 2. So in a general case, or in the case of a non-uniformly loaded bus, it is advisable to check the sense line at several locations along the length of the bus to determine the worst-case crosstalk. The measurement should be made for both the positive and the negative transition of the drive signal.

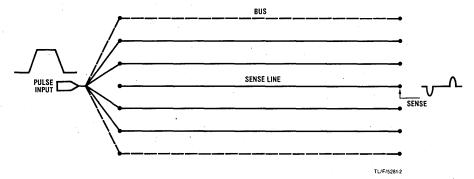
#### THE TERMINATION

A properly terminated transmission line has no reflections. But a practical microcomputer bus is neither a perfect transmission line nor is it properly terminated under all conditions. The capacitive loading at discrete locations, such as a used card slot, act as sources of reflection. However, in the limiting case when the bus is uniformly populated with a large number of modules, the bus behaves like a lower impedance transmission line. The loaded impedance ' $Z_L$ ' of the bus is given by the expression:

$$Z_{L} = \frac{Z}{\sqrt{1 + C_{L}/C1}} \tag{8}$$

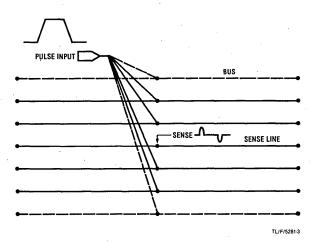
where Z = unloaded line impedance

Unfortunately, uniform loading of the bus is not guaranteed at all times and even if it were (by dummy loading of



Note: All lines terminated at both ends (not shown)

FIGURE 2. Worst-Case Far End Crosstalk Measurement



Note: All lines terminated at both ends (not shown)

FIGURE 3. Worst-Case Near End Crosstalk Measurement

the unused slots)  $Z_L$  is usually too low for proper termination of the bus. For example, a 10 pF per module loading of the 100 $\Omega$  microstrip bus at 0.6" spacing results in a  $Z_L$  = 30 $\Omega$ . One such termination at each end will require a 200 mA drive capacity on the bus driver for a nominal 3V swing. Such large drive currents and low value terminations increase the power dissipation of the system significantly in addition to causing other problems such as increased ground drop, inductive drops in traces due to large current being switched, etc. As a compromise the bus is usually terminated at an impedance higher than  $Z_L$  but less than or equal to Z. Consequently, there is always some amount of reflection present. For a perfect transmission line the reflection coefficient 'T' is given by the well known expression:

$$\Gamma = \frac{Z - R_t}{Z + R_t} \tag{9}$$

where Z = impedance of the bus  $R_t = termination$  resistance

The net effect, in the general case of a nonuniformly loaded bus, is that it may take several round trip bus delays after a bus driver output transition, before the quiescent voltage level is established. However, this delay is avoided by using a bus driver that has sufficient drive to generate a large enough voltage step during the first transition to cross well beyond the receiver threshold region under the worst-case load conditions.

Figure 4 illustrates the driver output waveform under such a condition. Here the fully loaded bus (with  $Z_L=30\Omega$ ), of the previous example, is driven by the DS3662 bus transceiver at the mid point. The driver is actually driving two transmission lines of  $Z_L=30\Omega$  in either direction from the middle and hence the initial step is given by:

$$V1 = \left(\frac{Z_L}{2}\right) 2I_S \tag{10}$$

where  $I_S$  = Standing current on the bus due to each termination

For the DS3662, the termination can be designed for  $2I_S = 100 \, \text{mA}$  and therefore:

$$V1 = (30/2)100 = 1.5V$$

This value of the initial swing is large enough to cross the narrow threshold region of the receiver as shown and therefore no waiting period is required for the reflections to build up the output high level. On the negative transition the problem is less critical due to the much higher sink capability of the DS3662 during pull down.

Reflections can also be caused by resistive loading of the bus by the DC input current of the receiver. The resulting reflection coefficient  $(\Gamma)$  is given by the expression:

$$\Gamma = -1/2 \, \left( \frac{I_{\rm R}}{I_{\rm S}} \right) \tag{11}$$

where I<sub>R</sub> = receiver input current

Having a receiver with a high input impedance not only makes this component of reflection insignificant but also reduces the DC load on the driver, allowing the use of lower value termination resistors. This is particularly true when a large number of modules are connected to the bus.

The design implications of the above discussion may be summarized as follows:

- 1. If the driver has adequate drive to produce the necessary voltage swing under the worst-case loading  $(Z_L/2)$ , reflections do not restrict the bus performance. This translates to a 100 mA minimum drive requirement for a typical microstrip bus.
- 2. If the drive is insufficient, time should be allowed for the reflections to build up the voltage level before the data is sampled.
- 3. For signals such as clock, strobe, etc., wherein the edge is used for triggering events, it is mandatory that the driver meet the above drive requirements if delayed or multiple triggering is to be avoided.
- 4. An ideal TTL bus transceiver should have at least a 100 mA drive, a high input impedance receiver with a narrow threshold uncertainty region.

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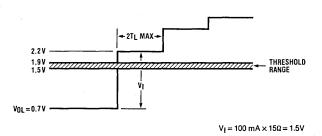


FIGURE 4. Worst-Case DS3662 Output Transition for  $Z_L = 15\Omega$  and  $R_T = 50\Omega$ 

#### THE DS3662 TRANSCEIVER

The DS3662 quad trapezoidal bus transceiver has been designed specifically to minimize the noise problems discussed previously. The driver generates precise trapezoidal waveforms that reduce crosstalk and the receiver uses a low pass filter to reject noise pulses having pulse widths up to the maximum driver output transition times. Precision output circuitry optimizes noise immunity without sacrificing the high data rate capability of Schottky transceivers.

Figure 5 shows the recommended configuration for microcomputer buses. The use of a 3.4V source with a single termination resistor at each end reduces the average power dissipation of the bus. However, a two resistor termination connected between the line and the power rails, having the same Thevenin's equivalent, can be substituted for lower cost.

Using a Miller integrator circuit, the driver generates a linearly rising and falling waveform with a constant slew rate of 0.2 VIns (Figure 7). This corresponds to a nominal transition time of 15 ns. Figure 6 compares the output waveform of a typical high speed driver to that of DS3662 under different load conditions. It should be noted that even under heavy loading, the regular drivers have peak slew rates that are much higher than the average. On the other hand, the trapezoidal waveform has a much lower slew rate with only a slight increase in the transition time. Such an increase in the transition time has little or no effect on the data rates. In fact, the high fidelity of the DS3662 driver output waveform allows pulse widths as low as 20 ns to be transmitted on the bus.

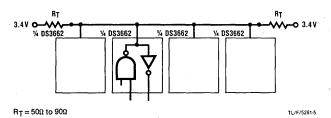
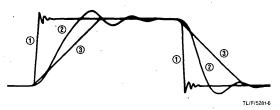


FIGURE 5. Recommended Bus Termination for Heavily Loaded Microstrip Backplanes



Note 1: Typical high speed driver output unloaded;  $t_r = t_f \approx 3$  ns

Note 2: Typical high speed driver output loaded;  $t_r = t_f \approx 10 \text{ ns}$ 

Note 3: Typical output of controlled slew rate driver which is load independent;  $t_r = t_f \approx 15$  ns

### FIGURE 6. Waveform Comparison

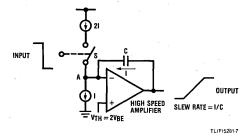


FIGURE 7. DS3662 Driver

The receiver consists of a low pass filter followed by a high speed comparator, with a typical threshold of 1.7V (Figure 8). The noise immunity of the receiver is specified in terms of the width of a 2.5V pulse that is guaranteed to be rejected by the receiver (Figure 9). The receiver typically rejects a 20 ns pulse going positive from the ground level or going negative from the 3.4V logic 1 level. The receiver threshold lies within a specified 400 mV region over the supply and temperature range and is centered between the low and high levels of the bus for a symmetrical noise margin

Other features of the device include a 100  $\mu\text{A}$  maximum DC bus loading specification under power ON or OFF condition and a glitch-free power up/down protection on the bus output.

Figure 10 shows the typical driver output waveform as compared to a standard high speed transceiver output. Oscillograms in Figure 11 demonstrate the ability of the receiver to distinguish the trapezoidal signal from noise. Here the receiver rejects a noise pulse of 19 ns width, while accepting a narrower signal pulse (16 ns) of the same peak amplitude (the signal is triangular because of the pulse width which is smaller than the transition time).

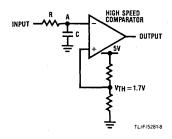
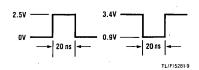
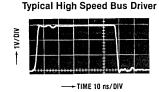


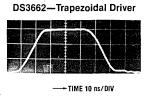
FIGURE 8. DS3662 Receiver



Rejects positive or negative going noise pulses of pulse widths up to 20 ns typical. Detects and propagates trapezoidal signal pulses in 20 ns typical.

FIGURE 9. Receiver Noise Immunity





TL/F/5281-10

FIGURE 10. Output Waveforms

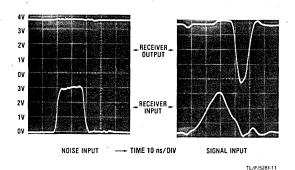


FIGURE 11. DS3662 Receiver Response

The performance of the transceiver under actual operating conditions is demonstrated in *Figure 12*. The oscillograms clearly show the capability of the DS3662 in real life situations. Here it is compared with the DS8834 under identical conditions. The transceivers drive a minicomputer bus (flat ribbon cable) 100 feet long, terminated at the far end with taps at various lengths for connecting to the receiver input. The cable is randomly folded to generate crosstalk between the various parts. In addition, a noise pulse induced on the signal line by driving an adja-

cent line with a pulse generator. As can be seen, the DS8834 device with fast rise and fall times on the driver output generates more crosstalk and its receiver easily responds to this crosstalk and to the externally induced noise (even though it has hysteresis!), limiting the useful length of the bus to less than 10 feet. In contrast, the DS3662's driver generates much less crosstalk and its receiver is immune to the induced noise even when the noise amplitude exceeds the signal amplitude as seen on the oscillogram at 50 feet.

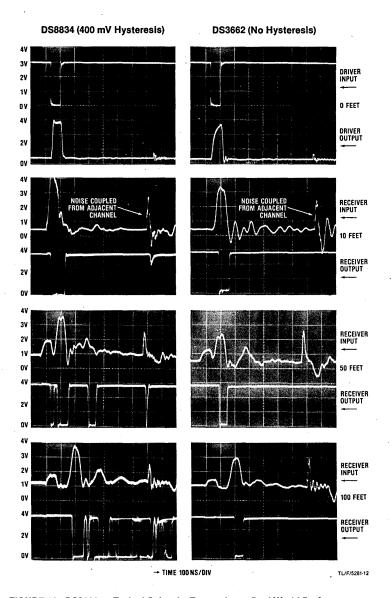


FIGURE 12. DS3662 vs Typical Schottky Transceiver—Real World Performance

Since crosstalk scales with the signal amplitude, reducing the signal swing has no effect on the noise immunity as long as the percentage noise margin remains the same. On the other hand, there are several advantages in having a lower signal swing. It reduces the drive current requirement of the driver thus reducing its output capacitance. Lower capacitive loading on the bus decreases its impedance reducing the drive requirement even further. Having a lower current drive not only reduces the power dissipated at the terminations but also allows better matching of the termination due to the increased line impedance. In the ideal limiting case the driver has negligible loading effect on the bus and thus allows perfect termination under all load conditions.

In practice however, there are some obvious limitations. The receiver thresholds have to be maintained within tighter limits at lower signal swings to maintain the same percentage noise margin. Also, the capacitive loading is difficult to reduce beyond a certain point, due to the diminishing return in the way of lower current rating, as the loaded bus impedance approaches the unloaded impedance. However, the capacitance of an open collector driver output can be reduced significantly by using a Schottky diode as shown in Figure 13. The diode isolates the driver capacitance when the output is disabled. Using reduced signal swings and precise receiver thresholds. such a transceiver can provide significant improvements in microcomputer bus performance.

#### CONCLUSION

A well designed bus transceiver goes a long way in improving the noise immunity of a single-ended TTL bus. Further improvements in bus performance may come from the use of reduced voltage swings and better transceiver designs for lower bus loading and tighter receiver threshold limits. Although such approaches may not be TTL compatible, the improvement in performance gained may indeed justify a new standard for bus transceivers.

#### REFERENCES

- 1) Bill Fowler, "Transmission Line Characteristics," National Semiconductor—Application Note 108, May 1974
- 2) A. Feller, H. P. Kaupp and J. J. Digiacomo, "Crosstalk And Reflections In High Speed Digital Systems," proceedings—Fall Joint Computer Conference, pp. 511-525, 1965
- 3) R. V. Balakrishnan, "Bus Optimizer," National Semiconductor-Application Note 259, April 1981
- 4) David Montgomery, "Borrowing RF Techniques For Digital Design," Computer Design, pp. 207-217, May 1982
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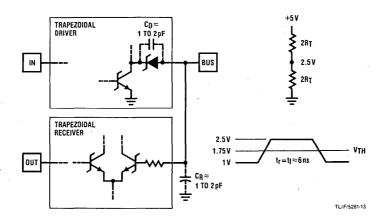


FIGURE 13. High Speed Bus Transceiver with Low Output Loading for Microcomputer Backplanes

# DS3666 IEEE-488 GPIB Transceiver

# **General Description**

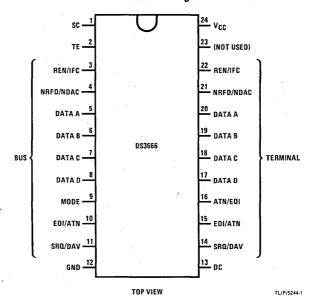
The DS3666 is a high-speed-Schottky 8-channel bidirectional transceiver designed to interface TTL/MOS logic to the IEEE Standard 488-1978 General Purpose Interface Bus. PNP inputs are used at all driver inputs for minimum loading, and hysteresis is provided at all receiver inputs for added noise margin. The IEEE-488 required bus termination is provided internally with an active turn-off feature which disconnects the termination from the bus when V<sub>CC</sub> is removed. A power up/down protection circuit is included at all bus outputs to provide glitch-free operation during  $V_{CC}$  power up or down. Implementing the IEEE-488 bus interface is accomplished by connecting two DS3666 devices together using the expansion control inputs provided. Each device is assigned to 4 data channels and 4 management signal channels to achieve the 16-line format.

### **Features**

- 8-channel bi-directional non-inverting transceivers
- Bi-directional control implemented with TRI-STATE® output design
- Meets IEEE Standard 488-1978
- High speed Schottky design
- Low power consumption
- High impedance PNP inputs (drivers)
- 500 mV (typ) input hysteresis (receivers)
- On-chip bus terminators
- No bus loading when V<sub>CC</sub> is removed
- Power up/down protection (glitch-free)
- Mode control implements 2-device expansion for complete IEEE-488 interface configuration
- Accommodates multi-controller systems

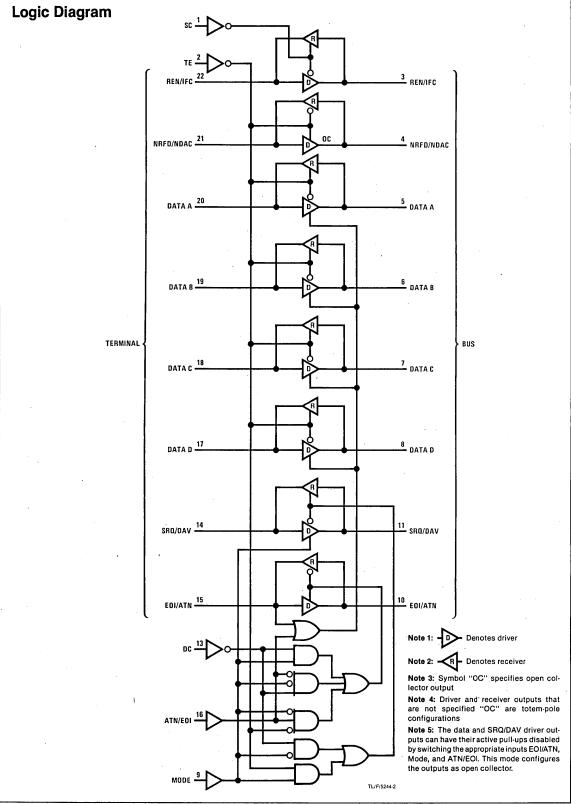
# **Connection Diagram**

#### **Dual-In-Line Package**



Order Number DS3666N See NS Package N24C

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### **Device Truth Tables**

#### TRANSCEIVER DIRECTION

Control Input Level				vel	Transceiver Signal Direction					
Mode	SC	TE	DC	ATN/EOI	REN/IFC	NRFD/NDAC	SRQ/DAV	EOI/ATN	Data	
х	н	x	x	х	т					
х	L	Х	x	х	R				ĺ	
x	Х	н	×Ι	x	ĺ	R		l	T	
x	Х	L	×	Χ.		Т ·			R	
Н	Х	Н	Х	Х			T			
н	Х	L	X	Х	1		R	1	] .	
н	Х	Х	н	· X	l			R		
н	X	_x	L	X	·			T		
L	Х	Х	Н	Х			Т			
L	Х	х	L	х	ĺ		R		1	
L	Х	Ή.	×	н				T	'	
L	Х	L	×	н	l			R	1	
L	Х	х	н	L	'		i ,	R	1 .	
L	Х	Х	L	L			•	T		

#### **OUTPUT CONFIGURATION**

	Control Input	Level	Transceiver Bus Output Configuration			
Mode ATN/EOI		ATN/EOI EOI/ATN* Data				
Х	н	н.	Totem-Pole			
Х	н	L	Totem-Pole			
Χ	L	н	Totem-Pole			
X	L	j L j	Open Collector			
Н	x	x		Totem-Pole		
L	x	x		Open Collector		

H = High level input

L = Low level input

X = Don't care

T = Transmit, i.e., signal outputted to bus

R = Receive, i.e., signal outputted to terminal

# **Functional Description**

The DS3666 is an 8-channel bi-directional transceiver with internal logic specifically configured to implement the IEEE-488 bus interface. Expansion logic is included so that two DS3666 devices may be interconnected to form the complete 16-line interface. This approach is equivalent to pairing the DS75160A and the DS75162A devices to implement the 16-line bus. The port connections to the bus lines have internal terminators, in accordance with the IEEE-488 Standard, that are deactivated when the device is powered down. This feature guarantees no bus loading when V<sub>CC</sub>=0V. The bus port data outputs have a control mode that either enables or disables the active upper stage of the totem-pole configuration. When the upper stage is disabled, the data outputs operate as open collector outputs, which are necessary for parallel polling. In compliance with the system organization of the management signal lines, the NRFD/NDAC bus port output is a fixed open collector configuration. Also, the SRQ/DAV bus port output is configured so that the SRQ output is open collector in the expanded implementation of the device. Transceiver direction control is divided into three groups. The NRFD/NDAC and data lines are controlled by the TE input. The REN/IFC line is controlled by the SC input. And

the EOI/ATN and SRQ/DAV lines are controlled by the TE or DC input, depending on the expansion mode. A special case is the direction of the designated EOI line, which is a function of both the TE and DC inputs, as well as the logic level present on the ATN line.

TABLE OF SIGNAL LINE ABBREVIATIONS

Signal Line Classification	Mnemonic	Definition
	DC	Direction Control
Control   Signals	TE	Talk Enable
Signals	sc	System Controller
Data I/O Ports	Data A, Data B, Data C, Data D	Bi-directional Data Transceivers
	ATN	Attention
	DAV	Data Valid
	EOI	End or Identify
Management	IFC	Interface Clear
Signals	NDAC	Not Data Accepted
	. NRFD	Not Ready for Data
	REN	Remote Enable
	SRQ	Service Request

<sup>\*</sup>The EOI/ATN transceiver signal level is sensed for internal logic control of bus port data output configuration

# IEEE-488 Interface Configuration Truth Tables (see Configuration Diagram)

### **MANAGEMENT SIGNALS**

Co	ntrol Ir	put Le		i		Transc	elver S	gnal D	irection		
SC	TE	DC	A	N"	EOI	REN	IFC	SRQ	NRFD	NDAC	DAV
н	н	н		R		Т	Т	Т	R	R	Т
н	н	L		Т		Т	Т	R	R	R	Т
Н	L	н		R	Ì	Т	Т	Т	Т	T	R
н	L	L		Т		Т	Т	R	Т	Ι Τ	R
L	Н	н		R		R	R	T	R	R	Т
L	н	L		Т	ŀ	R	R	R	R	R	Т
L	L	Н		R	İ	R	R	Т	Т	Т	R
L	L	L		Т	i	R	R	R	Т	Т	R
X	Н	X	Н		T						
X	L	×	Н		R						
Χ	×	н	L		R				1		
Х	х	L,	L		т				l		

### **DATA SIGNALS**

Contro	I Input	Level	Data Transceivers			
ATN EOI TE			Direction	<b>Bus Port Configuration</b>		
Х	Х	L	R	Input		
н	н	н	Т	Totem-Pole Output		
н	L	Н	Т	Totem-Pole Output		
L	Н	н	Т	Totem-Pole Output		
L	L	н	Т	Open Collector Output		

H = High level input

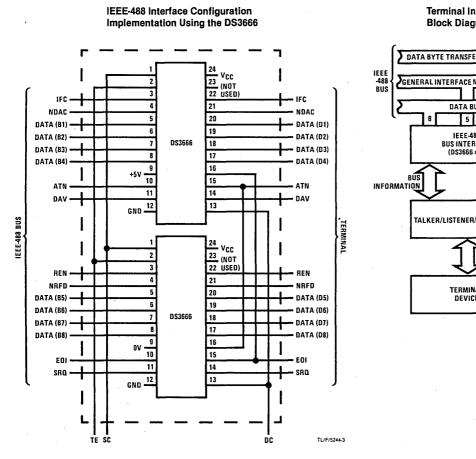
L = Low level input

X = Don't care

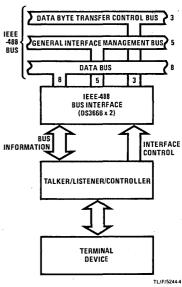
T = Transmit, i.e., signal outputted to bus

R = Receive, i.e., signal outputted to terminal

<sup>\*</sup>The ATN signal level is sensed for internal multiplex control of EOI transmission direction logic



### **Terminal Interface Block Diagram**



# Absolute Maximum Ratings (Note 1)

# **Operating Conditions**

	,		IVIII	wax	Units
Supply Voltage, V <sub>CC</sub>	7.0V	V <sub>CC</sub> , Supply Voltage	4.75	5.25	٧
Input Voltage	5.5V	T <sub>A</sub> , Ambient Temperature	0	70	°C
Storage Temperature Range	- 65°C to 150°C	I <sub>OL</sub> , Output Low Current: Bus		48	mΑ
Maximum Power Dissipation* at 25°C		Termina	al	16	mA
Molded Package	2005 mW				
Lead Temperature (Soldering, 10 second	s) 300°C				

<sup>\*</sup>Derate molded package 16.0 mW/°C above 25°C.

# Electrical Characteristics (Notes 2 and 3)

	Parameter			Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	High-Level Input Vol	tage			2			٧
V <sub>IL</sub>	Low-Level Input Volt	age					0.8	٧
VIK	Input Clamp Voltage	•	l <sub>1</sub> = – 18 m	I <sub>I</sub> = - 18 mA		- 0.8	-1.5	٧
V <sub>HYS</sub>	Input Hysteresis	Bus				500		m۷
V <sub>OH</sub>	High-Level Output Voltage	Terminal Bus (Note 5)		$I_{OH} = -800 \mu\text{A}$ $I_{OH} = -5.2 \text{mA}$		3.5		٧
V <sub>OL</sub>	Low-Level Output Voltage	Terminal Bus	I <sub>OL</sub> = 16 m	A		0.3	0.5 0.5	V
I <sub>IH</sub>	High-Level Input Current	Terminal and	$V_1 = 5.5V$ $V_1 = 2.7V$ $V_1 = 0.5V$		-	0.2	100 20	μΑ
I <sub>IL</sub>	Low-Level Input Current	Control Inputs			·	-10	-100	μΑ
V <sub>BIAS</sub>	Terminator Bias Voltage at Bus Port		Driver Disabled	I <sub>I(bus)</sub> = 0 (No Load)	2.5	3.0	3.7	٧
I <sub>LOAD</sub>	Terminator			$V_{I(bus)} = -1.5V \text{ to } 0.4V$	-1.3			
	Bus Loading			$V_{I(bus)} = 0.4V \text{ to } 2.5V$	0		- 3.2	mA
	Current	Bus	Driver Disabled	$V_{I(bus)} = 2.5V \text{ to } 3.7V$		·	2.5 - 3.2	
		•		$V_{I(bus)} = 3.7V \text{ to 5V}$	0		2.5	1
		•		$V_{l(bus)} = 5V \text{ to } 5.5V$	0.7		2.5	]
			$V_{CC} = 0, V$	<sub>I(bus)</sub> = 0V to 2.5V			40	μΑ
los	Short-Circuit	Terminal	V 2V. V-	= 0V (Note 4)	<b>– 15</b>	<b>– 35</b>	<b>– 75</b>	mA
	Output Current	Bus (Note 5)	V  - 2 V, VC	) == 0 V (NOTE 4)	<b>– 35</b>	<b>– 75</b>	<b>– 150</b>	111/2
I <sub>CC</sub>	Supply Current		V <sub>I</sub> = 0.8V, SC = 2.0V, TE = 2.0V, DC = 2.0V, Mode = 2.0V, ATN/EOI = 2.0V			90	135	mA
C <sub>IN</sub>	Bus-Port Capacitance	Bus	V <sub>CC</sub> = 5V o	or 0V, V <sub>I</sub> = 0V to 2V,		20	30	pF

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the 0°C to +70°C temperature range and the 4.75V to 5.25V power supply range. All typical values are for  $T_A = 25$ °C and  $V_{CC} = 5.0$ V.

Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max or min are so classified on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: This characteristic does not apply to the NRFD/NDAC bus output since it is open collector.

# Switching Characteristics $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0$ °C to 70°C (Note 1)

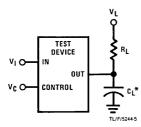
	Parameter	From	То	Conditions	Min	Тур	Max	Units			
t <sub>PLH</sub>	Propagation Delay Time, Low to High Level Output	Torminal	D	$V_L = 2.3V$ $R_L = 38.3\Omega$		10	20				
t <sub>PHL</sub>	Propagation Delay Time, High to Low Level Output	Terminal	Bus	C <sub>L</sub> = 30 pF Figure 1		14	20	ns			
t <sub>PLH</sub>	Propagation Delay Time, Low to High Level Output	B	Terminal	$V_L = 5.0V$ $R_L = 240\Omega$		14	20				
t <sub>PHL</sub>	Propagation Delay Time, High to Low Level Output	Bus	Terminai	C <sub>L</sub> = 30 pF Figure 2		10	20	ns			
t <sub>PZH</sub>	Output Enable Time to High Level	Control Inputs (Note 2) (Note 3)		$V_{L} = 3.0V$ $V_{L} = 0V$ $R_{L} = 480\Omega$		23	40	ns			
t <sub>PHZ</sub>	Output Disable Time from High Level					$C_{L} = 15 \text{ pF}$ Figure 1			15	. 27	115
t <sub>PZL</sub>	Output Enable Time to Low Level		bus	$V_{l} = 0V$ $V_{L} = 2.3V$ $R_{L} = 38.3\Omega$ $C_{L} = 15 \text{ pF}$ Figure 1		28	48				
t <sub>PLZ</sub>	Output Disable Time from Low Level					17	35	ns			
t <sub>PZH</sub>	Output Enable Time to High Level			V <sub>I</sub> = 3.0V V <sub>L</sub> = 0V		18	45				
t <sub>PHZ</sub>	Output Disable Time from High Level	Control	Control Inputs		.	$R_{L} = 3 k\Omega$ $C_{L} = 15 pF$ $Figure 1$		22	33	ns	
t <sub>PZL</sub>	Output Enable Time to Low Level	(Note 2) (Note 3)	Terminal	$V_{l} = 0V$ $V_{L} = 5V$		28	56				
t <sub>PLZ</sub>	Output Disable Time from Low Level			$R_L = 280\Omega$ $C_L = 15 pF$ Figure 1		20	35	ns			
t <sub>PZH</sub>	Output Pull-Up Enable Time	ATN/EOI	Bus	$V_1 = 3V$ $V_L = 0V$		10	20				
t <sub>PHZ</sub>	Output Pull-Up Disable Time	Input (Note 2)	Data Outputs	1 - 1		10	20	ns			

Note 1: Typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25$ °C and are meant for reference only.

Note 2: Refer to functional truth table for control input definition.

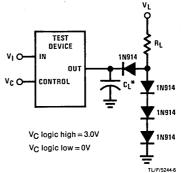
Note 3: Test configuration should be connected to only one transceiver at a time due to the high current stress caused by the V<sub>1</sub> voltage source when the output connected to that input becomes active.

# **Switching Load Configurations**



V<sub>C</sub> logic high = 3.0V V<sub>C</sub> logic low = 0V

FIGURE 1

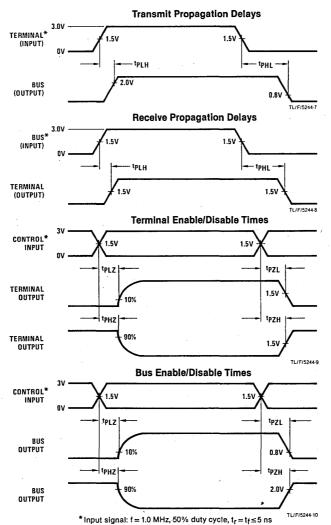


\*CL includes jig and probe capacitance

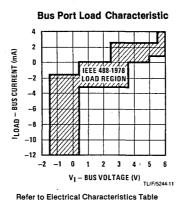
FIGURE 2

<sup>\*</sup>CL includes jig and probe capacitance

# **Switching Waveforms**



# **Performance Characteristics**



# **IEEE-488 Specification Summary**

**Logic Nomenclature.** When referring to the IEEE-488 specification publication, the following logic conventions are used:

- A "true" condition corresponds to a logic low signal level.
- A "false" condition corresponds to a logic high signal level.

**Bus Specification.** The IEEE-488 bus is comprised of 16 signal lines intended for digital data exchange at a maximum rate of 1 Mbaud and for a maximum transmission path length of 20 meters.

**Terminal Devices.** The IEEE-488 bus will support a maximum of 15 interconnected devices. These devices may be configured in four different modes of operation:

- 1) Talk only (e.g., counter)
- 2) Listen only (e.g., printer)
- 3) Listen and talk (e.g., multimeter)
- 4) Listen, talk, and control (e.g., calculator)

Data Bus. The data bus has 8 signal lines, denoted  $DIO_1$  through  $DIO_8$ . These lines carry data and interface messages in a bi-directional asynchronous, bit parallel, byte serial form.

Data Byte Transfer Control Bus. These 3 signal lines are used to control the transfer of data bytes across the data bus lines.

 NRFD (Not Ready for Data). This signal originates from a listen device and indicates to a talker that a listen device is not ready to accept data.

- DAV (Data Valid). This signal originates from a talker device and indicates to a listen device that data present on the data bus is valid.
- NDAC (Not Data Accepted). This signal originates from a listen device and indicates to a talker device that data on the data bus has not been accepted.

**General Interface Management Bus.** These 5 signal lines provide general management of all bus operations.

- ATN (Attention). This signal originates from a controller device and indicates to other devices on the bus how the data bus information is to be interpreted.
- IFC (Interface Clear). This signal originates from a controller device and causes all interface logic to be set to a known state.
- 3) REN (Remote Enable). This signal originates from a controller device and is used in conjunction with other messages to tell a remote device which of two sources of information is to be used. The source is designated as being remote or local.
- SRQ (Service Request). This signal is generated by a remote device to indicate to the controller device a need for attention.
- 5) EOI (End or Identify). This signal is generated by a talker device to indicate the end of a multibyte transfer. This signal may also originate from a controller, in conjunction with ATN to execute a polling sequence.

# **DS3667 TRI-STATE® Bidirectional Transceiver**

# **General Description**

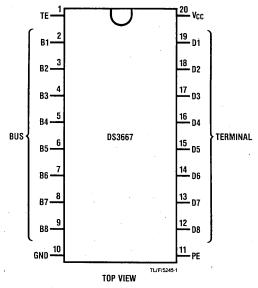
The DS3667 is a high speed Schottky 8-channel bidirectional transceiver designed for digital information and communication systems. Pin selectable totem-pole/open collector outputs are provided at all driver outputs. This feature, together with the Dumb Mode which puts both driver and receiver outputs in TRI-STATE at the same time, means higher flexibility of system design. PNP inputs are used at all driver inputs for minimum loading, and hysteresis is provided at all receiver inputs for added noise margin. A power up/down protection circuit is included at all outputs to provide glitch-free operation during  $V_{\rm CC}$  power up or down.

### **Features**

- 8-channel bidirectional non-inverting transceivers
- Bidirectional control implemented with TRI-STATE output design
- High speed Schottky design
- Low power consumption
- High impedance PNP inputs (drivers)
- Pin selectable totem-pole/open collector outputs (drivers)
- 500 mV (typ) input hysteresis (receivers)
- Power up/down protection (glitch-free)
- Dumb Mode capability

# **Connection Diagram**

### Dual-In-Line Package

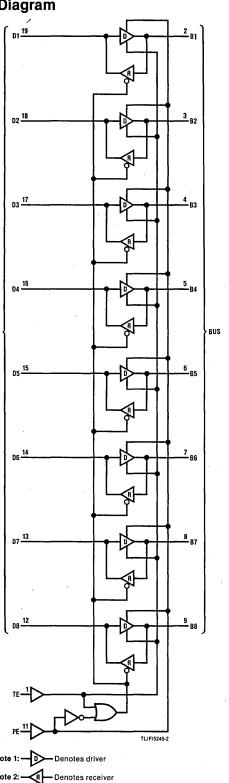


Order Number DS3667N See NS Package N20A

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# **Logic Diagram**

TERMINAL



# **Functional Truth Table**

Con Inp Le	out		Data Transceivers					
TE	PE	Mode	Bus Port	Terminal Port				
Н	Η	. Т	Totem-Pole Output	Input				
Н	L	Т	Open Collector Output	Input				
L	Н	R	Input	Output				
L	L	D	TRI-STATE	TRI-STATE				

- H: High Level Input
- L: Low Level Input
- T: Transmitting Mode
- R: Receiving Mode
- D: Dumb Mode

#### **Operating Conditions** Absolute Maximum Ratings (Note 1) Min Max Units 4.75 5.25 Supply Voltage, V<sub>CC</sub> 7.0V V<sub>CC</sub>, Supply Voltage 5.5V T<sub>A</sub>, Ambient Temperature 70 °C Input Voltage IOL, Output Low Current - 65°C to 150°C Storage Temperature Range Bus 48 mΑ Maximum Power Dissipation\* at 25°C Terminal 16 mΑ Molded Package 1832 mW Lead Temperature (Soldering, 10 seconds) 300°C

# Electrical Characteristics (Notes 2 and 3)

	Parameter	-	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	High Level Input Vo	oltage		2			٧
V <sub>IL</sub>	Low Level Input Vo	ltage				0.8	٧
V <sub>IK</sub>	Input Clamp Voltag	ge	I <sub>I</sub> = -18 mA		- 0.8	- 1.5	V
V <sub>HYS</sub>	Input Hysteresis	Bus		400	500		mV
V <sub>OH</sub>	High Level Output Voltage	Terminal Bus	$I_{OH} = -800 \mu\text{A}$ $I_{OH} = -5.2 \text{mA}$	2.7 2.5	3.5 3.4		V
V <sub>OL</sub>	Low Level Output Voltage	Terminal Bus	I <sub>OL</sub> = 16 mA I <sub>OL</sub> = 48 mA		0.3	0.5 0.5	v
1 <sub>1H</sub>	High Level Input Current	TE, PE	V <sub>1</sub> = 5.5V V <sub>1</sub> = 2.7V	4 .	0.2 0.1	100 20	μΑ
		Terminal and Bus	V <sub>1</sub> = 4V			200	
I <sub>IL</sub>	Low Level Input Current	Terminal and TE, PE Bus	V <sub>1</sub> = 0.5V		-10 -0.4	- 100 1.0	μA mA
Ios	Short Circuit Output Current	Terminal Bus	V <sub>I</sub> = 2V, V <sub>O</sub> = 0V (Note 4)	- 15 - 50	- 35 - 120	- 75 - 200	mA
I <sub>CC</sub>	Supply Current	•	Transmit, TE = 2V, PE = 2V, $V_1 = 0.8V$ Receive, TE = 0.8V, PE = 2V, $V_1 = 0.8V$	,	75 65	100 90	mA
C <sub>IN</sub>	Bus-Port Capacitance	Bus	V <sub>CC</sub> = 0V, V <sub>I</sub> = 0V, f = 10 kHz (Note 5)		20	30	pF

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the 0°C to +70°C temperature range and the 4.75V to 5.25V power supply range. All typical values are for  $T_A = 25$ °C and  $V_{CC} = 5.0$ V.

Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max or min are so classified on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: This parameter is guaranteed by design. It is not a tested parameter.

<sup>\*</sup>Derate molded package 14.7 mW/°C above 25°C.

### Switching Characteristics $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0$ °C to 70°C (Note 1)

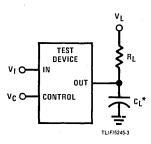
	Parameter	From	То	Conditions	Min	Тур	Max	Units
t <sub>PLH</sub>	Propagation Delay Time, Low to High Level Output	Terminal	Bus	$V_L = 2.3V$ $R_L = 38.3\Omega$		10	20	ns
t <sub>PHL</sub>	Propagation Delay Time, High to Low Level Output	reminai	Bus	C <sub>L</sub> =30 pF Figure 1		14	20	ns
t <sub>PLH</sub>	Propagation Delay Time, Low to High Level Output	Bus	Terminal	$V_L = 5.0V$ $R_L = 240\Omega$		15	20	ns
t <sub>PHL</sub>	Propagation Delay Time, High to Low Level Output	bus	remina	C <sub>L</sub> =30 pF Figure 2		10	20	ns
t <sub>PZH</sub>	Output Enable Time to High Level			$V_{L} = 3.0V$ $V_{L} = 0V$ $R_{L} = 480\Omega$		19	30	ns
t <sub>PHZ</sub>	Output Disable Time from High Level	TE (Note 2)	Bus	C <sub>L</sub> = 15 pF Figure 1		15	20	ns
t <sub>PZL</sub>	Output Enable Time to Low Level	(Note 3)	Bus	$V_1 = 0V$ $V_L = 2.3V$ $R_1 = 38.3\Omega$		24	40	ns
t <sub>PLZ</sub>	Output Disable Time from Low Level			C <sub>L</sub> = 15 pF Figure 1		17	30	ns
t <sub>PZH</sub>	Output Enable Time to High Level			$V_{l} = 3.0V$ $V_{L} = 0V$		19	35	ns
t <sub>PHZ</sub>	Output Disable Time from High Level	TE, PE (Note 2)	Terminal	$R_L = 3 \text{ k}\Omega$ $C_L = 15 \text{ pF}$ Figure 1		17	25	ns
t <sub>PZL</sub>	Output Enable Time to Low Level	(Note 3)	Terminai	$V_1 = 0V$ $V_L = 5V$ $R_1 = 280\Omega$		27	40	ns
t <sub>PLZ</sub>	Output Disable Time from Low Level			$C_L = 15 \text{ pF}$ Figure 1		17	30	ns
t <sub>PZH</sub>	Output Pull-Up Enable Time	PE	Bus	$V_1 = 3V$ $V_L = 0V$		10	20	ns
t <sub>PHZ</sub>	Output Pull-Up Disable Time	(Note 2)	Dus	$R_L = 480\Omega$ $C_L = 15 pF$ Figure 1		10	20	ns

Note 1: All typical values are for  $T_A = 25$  °C,  $V_{CC} = 5$ V.

Note 2: Refer to Functional Truth Table for control input definition.

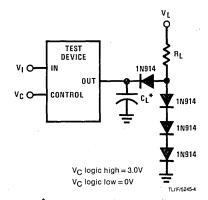
Note 3: Test configuration should be connected to only one transceiver at a time due to the high current stress caused by the V<sub>I</sub> voltage source when the output connected to that input becomes active.

### **Switching Load Configurations**



 $V_C$  logic high = 3.0V  $V_C$  logic low = 0V

FIGURE 1

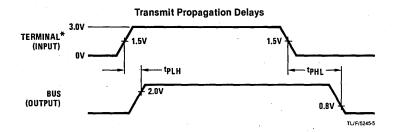


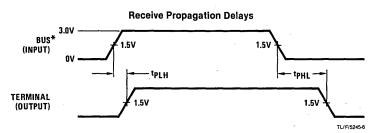
\* CL includes jig and probe capacitance

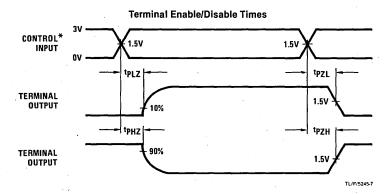
FIGURE 2

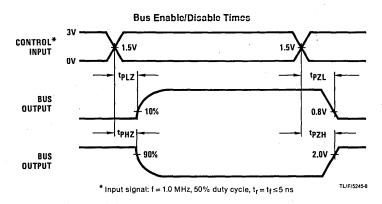
 $<sup>^{\</sup>star}$  C<sub>L</sub> includes jig and probe capacitance

### **Switching Waveforms**









## National Semiconductor

### DS75160A/DS75161A/DS75162A IEEE-488 GPIB Transceivers

### **General Description**

This family of high-speed-Schottky 8-channel bi-directional transceivers is designed to interface TTL/MOS logic to the IEEE Standard 488-1978 General Purpose Interface Bus (GPIB). PNP inputs are used at all driver inputs for minimum loading, and hysteresis is provided at all receiver inputs for added noise margin. The IEEE-488 required bus termination is provided internally with an active turn-off feature which disconnects the termination from the bus when V<sub>CC</sub> is removed. A power up/down protection circuit is included at all bus outputs to provide glitch-free operation during V<sub>CC</sub> power up or down.

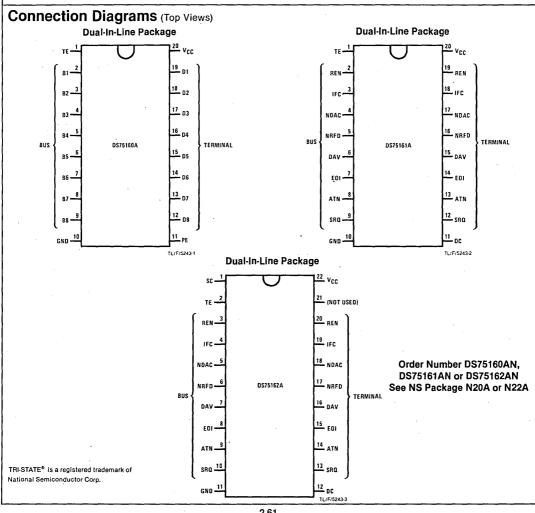
The General Purpose Interface Bus is comprised of 16 signal lines - 8 for data and 8 for interface management. The data lines are always implemented with DS75160A, and the management lines are either implemented with DS75161A in a single-controller system, or with DS75162A in a multi-controller system.

#### **Features**

- 8-channel bi-directional non-inverting transceivers
- Bi-directional control implemented with TRI-STATE® output design

**Bus Transceivers** 

- Meets IEEE Standard 488-1978
- High-speed Schottky design
- Low power consumption
- High impedance PNP inputs (drivers)
- 500 mV (typ) input hysteresis (receivers)
- On-chip bus terminators
- No bus loading when  $V_{CC}$  is removed
- Power up/down protection (glitch-free)
- Pin selectable open collector mode on DS75160A driver outputs
- Accommodates multi-controller systems



### **Functional Description**

#### DS75160A

This device is an 8-channel bi-directional transceiver with one common direction control input, denoted TE. When used to implement the IEEE-488 bus, this device is connected to the eight data bus lines, designated DIO<sub>1</sub>-DIO<sub>8</sub>. The port connections to the bus lines have internal terminators, in accordance with the IEEE-488 Standard, that are deactivated when the device is powered down. This feature guarantees no bus loading when  $V_{CC} = 0V$ . The bus port outputs also have a control mode that either enables or disables the active upper stage of the totem-pole configuration. When this control input, denoted PE, is in the high state, the bus outputs operate in the high-speed totem-pole mode. When PE is in the low state, the bus outputs operate as open collector outputs which are necessary for parallel polling.

#### DS75161A

This device is also an 8-channel bi-directional transceiver which is specifically configured to implement the eight management signal lines of the IEEE-488 bus. This device, paired with the DS75160A, forms the complete 16-line interface between the IEEE-488 bus and a single controller instrumentation system. In compliance with the system organization of the management signal lines, the SRQ, NDAC, and NRFD bus port outputs are open collector. In contrast to the DS75160A, these open collector outputs are a fixed configuration. The direction control is divided into three groups. The DAV, NDAC, and NRFD transceiver directions are controlled by the TE input. The ATN, SRQ, REN, and IFC transceiver directions are controlled by the DC input. The EOI transceiver direction is a function of both the TE and DC inputs, as well as the logic level present on the ATN channel. The port connections to the bus lines have internal terminators identical to the DS75160A.

#### DS75162A

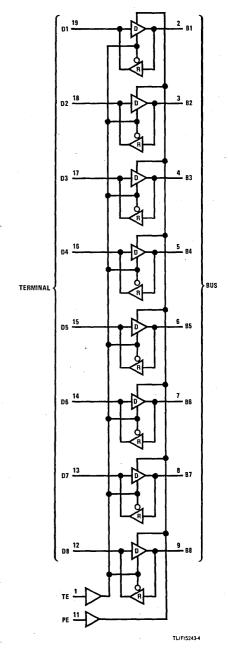
This device is identical to the DS75161A, except that an additional direction control input is provided, denoted SC. The SC input controls the direction of the REN and IFC transceivers that are normally controlled by the DC input on the DS75161A. This additional control function is instrumental in implementing multiple controller systems.

#### **TABLE OF SIGNAL LINE ABBREVIATIONS**

Signal Line Classification	Mnemonic	Definition	Device
	DC	Direction Control	DS75161A/DS75162A
Control	PE	Pull-Up Enable	DS75160A
Signals	TE	Talk Enable	All
[	SC	System Controller	DS75162A
Data	B1-B8	Bus Side of Device	DC754004
I/O Ports	D1-D8	Terminal Side of Device	DS75160A
	ATN	Attention	}
	DAV	Data Valid	]
	EOI	End or Identify	ì
Management	IFC	Interface Clear	DS75161A/DS75162A
Signals	NDAC	Not Data Accepted	DS/3101A/DS/3102A
i	NRFD	Not Ready for Data	1
}	REN	Remote Enable	1
<u> </u>	SRQ	Service Request	1

### **Logic Diagrams**

#### DS75160A



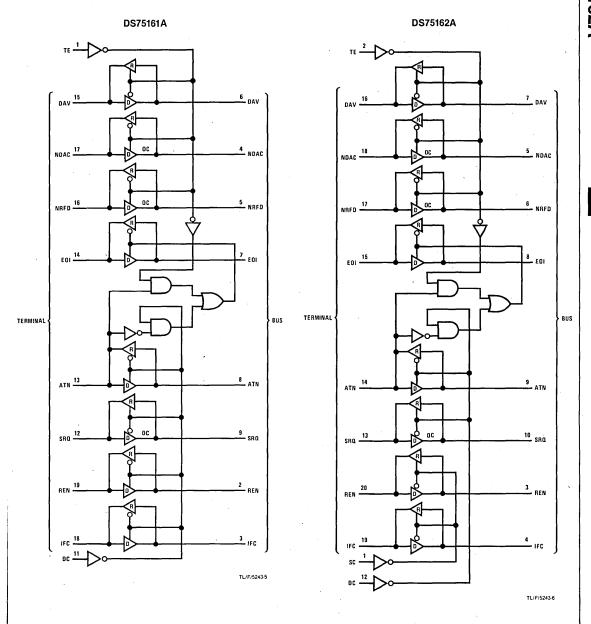
Denotes driver

Denotes receiver

Note 3: Driver and receiver outputs are totem-pole configurations

Note 4: The driver outputs of DS75160A can have their active pull-ups disabled by switching the PE input (pin 11) to the logic low state. This mode configures the outputs as open collector.

### Logic Diagrams (Continued)



Note 1: —D Denotes driver

Note 2: —R Denotes receiver

Note 3: Symbol "OC" specifies open collector output

Note 4: Driver and receiver outputs that are not specified "OC" are totem-pole configurations

<b>Absolute Maximum Ratings</b>	(Note 1)	<b>Operating Conditi</b>	ons		
•		•	Min	Max	Units
Supply Voltage, V <sub>CC</sub>	7.0V	V <sub>CC</sub> , Supply Voltage	4.75	5.25	٧
Input Voltage	5.5V	T <sub>A</sub> , Ambient Temperature	0	70	°C
Storage Temperature Range	- 65°C to 150°C	IOL, Output Low Current			
Maximum Power Dissipation* at 25°C		Bus		48	mA
Molded Package	1897 mW	Terminal		16	mΑ
Lead Temperature (Soldering, 10 seconds)	300°C	*Derate molded package 15.2 mW/*	C above 25°0	Э.	

### Electrical Characteristics (Notes 2 and 3)

	Parameter			Conditions	Min	Тур	Max	Units
VIH	High-Level Input Vol	tage			. 2			٧
VIL	Low-Level Input Volt	age					0.8	٧
V <sub>IK</sub>	Input Clamp Voltage	)	l <sub>1</sub> = - 18 m	A		- 0.8	- 1.5	٧
V <sub>HYS</sub>	Input Hysteresis	Bus			400	500		m۷
V <sub>OH</sub>	High-Level	Terminal	I <sub>OH</sub> = -80	00 μΑ	2.7	3.5		· ·
	Output Voltage	Bus (Note 5)	$I_{OH} = -5.2$	2 mA	2.5	3.4		
VoL	Low-Level	Terminal	$I_{OL} = 16 \text{ m}$		i	0.3	0.5	V
	Output Voltage	Bus	$I_{OL} = 48 \text{ m}$	Α .		0.4	0.5	
I <sub>IH</sub>	High-Level	<b>-</b>	$V_i = 5.5V$			0.2	100	μΑ
	Input Current	Terminal and TE, PE, DC,	$V_1 = 2.7V$			0.1	20	μΛ
I <sub>IL</sub>	Low-Level Input Current	SC Inputs	V <sub>I</sub> = 0.5V	· · · · · · · · · · · · · · · · · · ·		-10	-100	μΑ
V <sub>BIAS</sub>	Terminator Bias Voltage at Bus Port		Driver Disabled	I <sub>I(bus)</sub> = 0 (No Load)	2.5	3.0	3.7	٧
I <sub>LOAD</sub>	Terminator			$V_{l(bus)} = -1.5V \text{ to } 0.4V$	-1.3			
	Bus Loading			$V_{l(bus)} = 0.4V \text{ to } 2.5V$	0		- 3.2	ŀ
	Current	Bus	Driver Disabled	$V_{l(bus)} = 2.5V \text{ to } 3.7V$	,		2.5 - 3.2	mA
				V <sub>I(bus)</sub> = 3.7V to 5V	0		2.5	
				$V_{I(bus)} = 5V \text{ to } 5.5V$	0.7		2.5	
			$V_{CC} = 0, V$	(bus) = 0V to 2.5V			40	μΑ
los	Short-Circuit	Terminal	V 2V V-	= 0V (Note 4)	- 15	- 35 ·	<del>- 7</del> 5	mA
	Output Current	Bus (Note 5)	VI - 2V, VC	)=0V (NOTE 4)	- 35	<b>– 75</b>	- 150	
1 <sub>CC</sub>	Supply Current	DS75160A		$TE = 2V, PE = 2V, V_1 = 0.8V$		85	125	
·UU 、	Cappiy Current			$E = 0.8V, PE = 2V, V_1 = 0.8V$		70	100	mA
		DS75161A		$DC = 0.8V, V_1 = 0.8V$		84	125 125	
		DS75162A	<u>-</u>	$DC = 0.8V$ , $SC = 2V$ , $V_1 = 0.8V$		85	<del></del>	<del> </del>
CIN	Bus-Port	Bus		or $0V$ , $V_1 = 0V$ to $2V$ ,		20	30	pF
	Capacitance		f = 1 MHz			L		

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the 0°C to +70°C temperature range and the 4.75V to 5.25V power supply range. All typical values are for T<sub>A</sub> = 25°C and V<sub>CC</sub> = 5.0V.

Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max or min are so classified on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: This characteristic does not apply to outputs on DS75161A and DS75162A that are open collector.

### Switching Characteristics $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0$ °C to 70°C (Note 1)

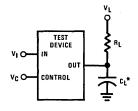
	Parameter	From	То	Conditions	DS	7516	0A	DS	7516	1A	DS	7516	2A	Units
	Parameter	FIOIII	10	Conditions	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Oilles
t <sub>PLH</sub>	Propagation Delay Time, Low to High Level Output	Terminal	Bus	$V_L = 2.3V$ $R_L = 38.3\Omega$		10	20		10	20		10	20	ns
t <sub>PHL</sub>	Propagation Delay Time, High to Low Level Output	Terminar	Bus	C <sub>L</sub> =30 pF Figure 1		14	20		14	20		14	20	ns
t <sub>PLH</sub>	Propagation Delay Time, Low to High Level Output	Bus	Terminal	$V_L = 5.0V$ $R_L = 240\Omega$		14	20		14	20		14	20	ns
t <sub>PHL</sub>	Propagation Delay Time, High to Low Level Output	Dus	Terminal	C <sub>L</sub> =30 pF Figure 2		10	20		10	20		10	20	ns
t <sub>PZH</sub>	Output Enable Time to High Level			$V_1 = 3.0V$ $V_L = 0V$ $R_L = 480\Omega$		19	32		23	40		23	40	ns
t <sub>PHZ</sub>	Output Disable Time from High Level	TE, DC, or SC	Bus	C <sub>L</sub> = 15 pF Figure 1		15	22		15	25		15	25	ns
t <sub>PZL</sub>	Output Enable Time to Low Level	(Note 2) (Note 3)	Bus	$V_{L} = 0V$ $V_{L} = 2.3V$ $R_{1} = 38.3\Omega$		24	35		28	48		28	48	ns
t <sub>PLZ</sub>	Output Disable Time from Low Level			$C_L = 15 \text{ pF}$ Figure 1		17	25		17	27		17	27	ns
t <sub>PZH</sub>	Output Enable Time to High Level			$V_1 = 3.0V$ $V_L = 0V$ $R_1 = 3 \text{ k}\Omega$		17	33		18	40		18	40	ns
t <sub>PHZ</sub>	Output Disable Time from High Level	TE, DC, or SC	Terminal	C <sub>L</sub> =15 pF Figure 1		15	25		22	33		22	33	ns
t <sub>PZL</sub>	Output Enable Time to Low Level	(Note 2) (Note 3)	Terminar	$V_1 = 0V$ $V_L = 5V$ $R_L = 280\Omega$		25	39		28	52		28	52	ns
t <sub>PLZ</sub>	Output Disable Time from Low Level			$C_L = 15 \text{ pF}$ Figure 1		15	27		20	35		20	35	ns
t <sub>PZH</sub>	Output Pull-Up Enable Time (DS75160A Only)	PE	Bus	$V_1 = 3V$ $V_L = 0V$ $R_1 = 480\Omega$		10	17		NA			NA		ns
tpHZ	Output Pull-Up Disable Time (DS75160A Only)	(Note 2)	Bus	$C_L = 15 \text{ pF}$ Figure 1		10	15		NA			NA		ns

Note 1: Typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25$  °C and are meant for reference only.

Note 2: Refer to Functional Truth Tables for control input definition.

Note 3: Test configuration should be connected to only one transceiver at a time due to the high current stress caused by the V<sub>I</sub> voltage source when the output connected to that input becomes active.

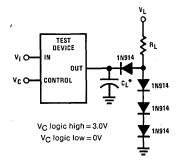
### **Switching Load Configurations**



V<sub>C</sub> logic high = 3.0V V<sub>C</sub> logic low = 0V

FIGURE 1

· TL/F/5243-7



\*C<sub>L</sub> includes jig and probe capacitance

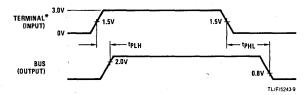
FIGURE 2

TL/F/5243-8

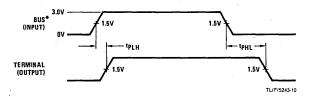
<sup>\*</sup>CL includes jig and probe capacitance



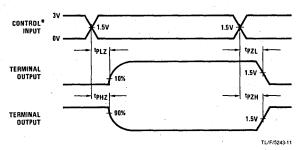
#### **Transmit Propagation Delays**



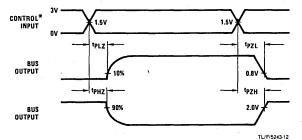
#### **Receive Propagation Delays**



#### Terminal Enable/Disable Times



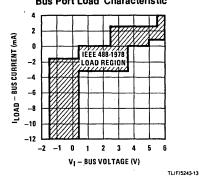
#### **Bus Enable/Disable Times**



\* Input signal: f = 1.0 MHz, 50% duty cycle,  $t_f = t_f \le 5$  ns

### **Performance Characteristics**

### **Bus Port Load Characteristic**



Refer to Electrical Characteristics table

### **Functional Truth Tables**

#### DS75160A

1	ol Input evel	Data Transceivers					
TE	PE	Direction	<b>Bus Port Configuration</b>				
H	Н	Т	Totem-Pole Output				
н	L	Т	Open Collector Output				
L	Х	R	Input				

#### DS75161A

Contr	Control Input Level			Transceiver Signal Direction							
TE	DC	A <sup>-</sup>	TN*	EOI	REN	IFC	SRQ	NRFD	NDAC	DAV	
Н	H		R		R	R	Т	R	R	Т	
Н	L		Т		Т	T	R	R	R	Т	
L	н		R		R	R	Т	Т	Т	R	
L	L		Т		Т	Т	R	Т	T	R	
Н	X	H		T							
L	Х	Н		R					•		
X	Н	L		R							
X	,L	L		Т	İ						

#### DS75162A

C	ontrol l	nput Le	vel			Transc	eiver S	ignal D	irection	1	
sc	TE	DC	А	TN*	EOI	REN	IFC	SRQ	NRFD	NDAC	DAV
Н	Н	Н		R	-	Т	T	T	R	R	Т
Н	н	L		Т		Т	Т	R	R	R	T
Н	L	н		R		Т	Т	Т	Т	Т	R
н	L	L		т		Т	Т	R	Т	Т	R
L	н	Н		R		R	R	Т	R	R	Т
L	н	L		Т		R	R	R	R	R	Т
L	L	Н		R		R	R	Т	Т	Т	R
L_	_ L	L		Т		R	R	·R	Т	Т	R
Х	Н	Х	Н		Т						
Х	L	х	н		R						
X	X	Н	L		R						
X	Х	L	L		Т						L

H = High level input

L = Low level input

X ≈ Don't care

T = Transmit, i.e., signal outputted to bus

R = Receive, i.e., signal outputted to terminal

<sup>\*</sup>The ATN signal level is sensed for internal multiplex control of EOI transmission direction logic



### **Bus Transceivers**

### DS7640/DS8640 Quad NOR Unified Bus Receiver

### **General Description**

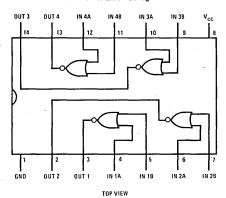
The DS7640 and DS8640 are quad 2-input receivers designed for use in bus organized data transmission systems interconnected by terminated  $120\Omega$  impedance lines. The external termination is intended to be  $180\Omega$  resistor from the bus to the +5V logic supply together with a  $390\Omega$  resistor from the bus to ground. The design employs a built-in input threshold providing substantial noise immunity. Low input current allows up to 27 driver/receiver pairs to utilize a common bus.

### **Features**

- Low input current with normal  $V_{CC}$  or  $V_{CC} = 0V$  (30 $\mu$ A typ)
- High noise immunity (1.1V typ)
- Temperature-insensitive input thresholds track bus logic levels
- TTL compatible output
- Matched, optimized noise immunity for "1" and "0" levels
- High speed (19 ns typ)

### **Connection Diagram**

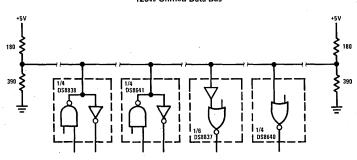
#### Dual-In-Line Package



Order Number DS7640J, DS8640J or DS8640N See NS Package J14A or N14A

### **Typical Application**

120Ω Unified Data Bus



Absolute Maximum Rati	ngs (Note 1)	Operating Condi	tions		
		_	MIN	MAX	UNITS
Supply Voltage	7.0V	Supply Voltage (V <sub>CC</sub> )			
Input Voltage	5.5V	DS7640	4.5	5.5	V
Storage Temperature Range	-65°C to +150°C	D\$8640	4.75	5.25	V
Maximum Power Dissipation* at 25°C Cavity Package	1308 mW	Temperature (T <sub>A</sub> ) DS7640	-55	+125	°C
Molded Package Lead Temperature (Soldering, 10 seconds)	1207 mW 300°C	D\$8640	0	+70	°C
*Derate cavity package 8.7 mW/°C above 29 package 9.7 mW/°C above 25°C.	5°C; derate molded				

#### **Electrical Characteristics**

The following apply for  $V_{MIN} \le V_{CC} \le V_{MAX}$ ,  $T_{MIN} \le T_A \le T_{MAX}$ , unless otherwise specified (Notes 2 and 3)

	PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	High Level Input Threshold	V - V	DS7640	1.80	1.50		V
		V <sub>OUT</sub> = V <sub>OL</sub>	DS8640	1.70	1.50		V
VIL	Low Level Input Threshold	V -'V	DS7640		1.50	1.20	٧
		V <sub>OUT</sub> = V <sub>OH</sub>	DS8640		1.50	1.30	V
I <sub>iH</sub> Max	kimum Input Current	V - 4V	V <sub>CC</sub> = V <sub>MAX</sub>		30	80	μΑ
		V <sub>IN</sub> = 4V	V <sub>CC</sub> = 0V		1.0	50	μΑ
I <sub>IL</sub>	Maximum Input Current	V <sub>IN</sub> = 0.4V, V <sub>CC</sub> = \	/ <sub>MAX</sub>		1.0	50	μΑ
Voh	Output Voltage	I <sub>OH</sub> = -400μA, V <sub>IN</sub>	= V <sub>IL</sub>	2.4			٧
VoL	Output Voltage	I <sub>OL</sub> = 16 mA, V <sub>IN</sub> =	V <sub>iH</sub>		0.25	0.4	٧
los	Output Short Circuit Current	V <sub>IN</sub> = 0.5V, V <sub>OS</sub> = 0	OV, V <sub>CC</sub> = V <sub>MAX</sub> , (Note 4)	-18		-55	mA
Icc	Power Supply Current	V <sub>IN</sub> = 4V, (Per Packa	ge)		25	40	mA

### **Switching Characteristics** T<sub>A</sub> = 25°C, nominal power supplies unless otherwise noted

	PARAMETER	CON	IDITIONS	MIN	ТҮР	MAX	UNITS
t <sub>pd</sub>	Propagation Delays	(Notes 5 and 6)	Input to Logic "1" Output	10	23	35	ns
		(Notes 5 and 6)	Input to Logic "0" Output	10	15	30	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS7640 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8640. All typical values are for  $T_{A} = 25^{\circ}$ C and  $V_{CC} = 5V$ .

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: Fan-out of 10 load,  $C_{LOAD}$  = 15 pF total, measured from  $V_{IN}$  = 1.5V to  $V_{OUT}$  = 1.5V,  $V_{IN}$  = 0V to 3V pulse.

Note 6: Apply for  $V_{CC} = 5V$ ,  $T_A = 25^{\circ}C$ .

### **Bus Transceivers**

### DS7641/DS8641 Quad Unified Bus Transceiver

### **General Description**

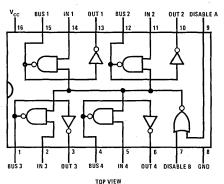
The DS7641 and DS8641 are quad high speed drivers/ receivers designed for use in bus organized data transmission systems interconnected by terminated  $120\Omega$  impedance lines. The external termination is intended to be a  $180\Omega$  resistor from the bus to the +5V logic supply together with a  $390\Omega$  resistor from the bus to ground. The bus can be terminated at one or both ends. Low bus pin current allows up to 27 driver/receiver pairs to utilize a common bus. The bus loading is unchanged when  $V_{CC}=0V$ . The receivers incorporate tight thresholds for better bus noise immunity. One two-input NOR gate is included to disable all drivers in a package simultaneously.

#### **Features**

- 4 separate driver/receiver pairs per package
- Guaranteed minimum bus noise immunity of 0.6V, 1.1V typ
- Temperature insensitive receiver thresholds track bus logic levels
- = 30 $\mu$ A typical bus terminal current with normal  $V_{CC}$  or with  $V_{CC}$  = 0V
- Open collector driver output allows wire-OR connection
- High speed
- Series 74 TTL compatible driver and disable inputs and receiver outputs

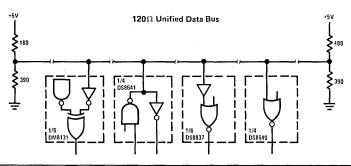
### **Connection Diagram**

#### Dual-In-Line Package



Order Number DS7641J, DS8641J or DS8641N See NS Package J16A or N16A

### **Typical Application**



#### **Operating Conditions** Absolute Maximum Ratings (Note 1) UNITS MAX 7V Supply Voltage Supply Voltage, (VCC) 5.5V 4.5 5.5 Input and Output Voltage DS7641 Storage Temperature Range -65°C to +150°C DS8641 4.75 5.25 Maximum Power Dissipation\* at 25°C Temperature Range, (TA) 1433 mW Cavity Package °C DS7641 -55 +125 Molded Package 1362 mW DS8641 0 +70 °C Lead Temperature (Soldering, 10 seconds) 300°C \*Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.9 mW/°C above 25°C.

#### **Electrical Characteristics**

The following apply for  $V_{MIN} \le V_{CC} \le V_{MAX}$ ,  $T_{MIN} \le T_A \le T_{MAX}$  unless otherwise specified (Notes 2 and 3)

	PARAMETER	CONDITIONS	<b>.</b>	MIN	TYP	MAX	UNITS
DRIV	ER AND DISABLE INPUTS						
V <sub>IH</sub>	Logical "1" Input Voltage			2.0			v
VIL	Logical "0" Input Voltage	-				0.8	V
I <sub>1</sub>	Logical "1" Input Current	V <sub>IN</sub> = 5.5V				1	mA
I <sub>IH</sub>	Logical "1" Input Current	V <sub>IN</sub> = 2.4V				40	μΑ
IIL	Logical "0" Input Current	V <sub>IN</sub> = 0.4V				-1.6	mA
V <sub>CL</sub>	Input Diode Clamp Voltage	$I_{DIS} = -12 \text{ mA}, I_{IN} = -12 \text{ mA}, I_{BI}$ $T_A = 25^{\circ}\text{C}$	<sub>JS</sub> = −12 mA,		-1	-1.5	٧
DRIV	ER OUTPUT/RECEIVER INPUT						
V <sub>OLB</sub>	Low Level Bus Voltage	$V_{DIS} = 0.8V$ , $V_{IN} = 2V$ , $I_{BUS} = 50$	) mA		0.4	0.7	V
I <sub>IHB</sub>	Maximum Bus Current	$V_{IN} = 0.8V, V_{BUS} = 4V, V_{CC} = V_{A}$	MAX		30	100	μΑ
IILB	Maximum Bus Current	$V_{1N} = 0.8V$ , $V_{BUS} = 4V$ , $V_{CC} = 0$	<b>v</b>		2	100	μА
VIH	High Level Receiver Threshold	V <sub>IND</sub> = 0.8V, V <sub>OL</sub> = 16 mA	DS7641	1.80	1.50		٧
		V <sub>IND</sub> - 0.8V, V <sub>OL</sub> - 10 mA	DS8641	1.70	1.50		٧
$V_{IL}$	Low Level Receiver Threshold	V <sub>IND</sub> = 0.8V, V <sub>OH</sub> = -400μA	DS7641		1.50	1.20	V
		V IND - 0.8V, VOH = -400µA	DS8641		1.50	1.30	V
RECE	IVER OUTPUT						
VoH	Logical "1" Output Voltage	$V_{IN} = 0.8V$ , $V_{BUS} = 0.5V$ , $I_{OH} = -$	-400µA	2.4			V
V <sub>OL</sub>	Logical "0" Output Voltage	V <sub>IN</sub> = 0.8V, V <sub>BUS</sub> = 4V, I <sub>OL</sub> = 16	mA		0.25	0.4	V
los	Output Short Circuit Current	$V_{DIS} = 0.8V$ , $V_{IN} = 0.8V$ , $V_{BUS} = V_{CC} = V_{MAX}$ , (Note 4)	0.5V, V <sub>OS</sub> = 0V,	-18		-55	mA
Icc	Supply Current	V <sub>DIS</sub> = 0V, V <sub>IN</sub> = 2V, (Per Packag	e)		50	70	mA

### Switching Characteristics T<sub>A</sub> = 25°C, V<sub>CC</sub> = 5V, unless otherwise noted

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd</sub>	Propagation Delays (Note 7) Disable to Bus "1" Disable to Bus "0" Driver Input to Bus "1" Driver Input to Bus "0"	(Note 5)		19 15 17	30 30 25 25	ns ns ns
	Bus to Logical "1" Receiver Output Bus to Logical "0" Receiver Output	(Note 6)		20 18	30	ns ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS7641 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8641. All typical values are for  $T_{A} = 25^{\circ}$ C and  $V_{CC} = 5$ V.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5:  $91\Omega$  from bus pin to V<sub>CC</sub> and  $200\Omega$  from bus pin to ground. C<sub>LOAD</sub> = 15 pF total. Measured from V<sub>IN</sub> = 1.5V to V<sub>BUS</sub>= 1.5V, V<sub>IN</sub> = 0V to 3V pulse.

Note 6: Fan-out of 10 load,  $C_{LOAD}$  = 15 pF total. Measured from  $V_{IN}$  = 1.5V to  $V_{OUT}$  = 1.5V,  $V_{IN}$  = 0V to 3V pulse.

Note 7: The following apply for  $V_{CC} = 5V$ ,  $T_A = 25^{\circ}C$  unless otherwise specified.

### **Bus Transceivers**

### **DS8642 Quad Transceiver**

### **General Description**

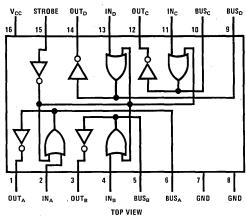
The DS8642 is a quad transceiver designed for bus organized data transmission systems terminated by  $50\Omega$  impedance. The bus can be terminated at one or both ends. It has four bus drivers with a common strobe gate and four bus receivers. Bus driver outputs can be "OR-tied" with up to 19 other drivers and with up to 20 bus receiver loads. The bus loading is 2k when  $V_{\text{CC}}=0\text{V}.$ 

#### **Features**

- 100 mA Drive Capability
- Four separate driver/receiver pairs
- Open collector driver output allows wire-OR connection
- 50 $\Omega$  line termination
- Completely TTL compatible on driver and disable inputs, and receiver outputs

### **Logic and Connection Diagram**

Dual-In-Line Package



Order Number DS8642J or DS8642N See NS Package J16A or N16A

### Absolute Maximum Ratings (Note 1)

### **Operating Conditions**

			MIN	MAX	UNITS
Supply Voltage	7V	Supply Voltage, VCC	4.75	5.25	V
Input Voltage	5.5V	Temperature, T <sub>A</sub>	n	+70	°C
Output Voltage	5.5V	remperature, 1 A	Ū	. 70	·
Storage Temperature Range	-65°C to +150°C				
Maximum Power Dissipation * at 25°C					
Cavity Package	1433 mW				
Molded Package	1362 mW				

300°C

Lead Temperature (Soldering, 10 seconds)

#### Electrical Characteristics (Notes 2 and 3)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
DISABL	E/DRIVER INPUT		*			
V <sub>IH</sub>	Logical "1" Input Voltage	V <sub>CC</sub> = Min	2			V
V <sub>IL</sub>	Logical "0" Input Voltage	V <sub>CC</sub> = Min			0.8	V
I <sub>IL</sub>	Logical "0" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V		-0.9	-1.6	mA
l <sub>ts</sub>	Logical "1" Input Current	$V_{CC} = Max \qquad \frac{V_{IN} = 2.4V}{V_{IN} = 5.5V}$			40	μA mA
V <sub>CD</sub>	Input Clamp Voltage	I <sub>IN</sub> = -12 mA		-0.8	-1.5	V
RECEIV	ER INPUT/BUS OUTPUT					<u> </u>
V <sub>IHB</sub>	Logical "1" Input Voltage	V <sub>CC</sub> = Max	3.1			V
VILB	Logical "0" Input Voltage	V <sub>CC</sub> = Min			1.4	٧
V <sub>CDB</sub>	Input Clamp Diode	I <sub>IN</sub> = -50 mA		-1.0	-1.5	V
I <sub>IHB</sub>	Logical "1" Input Current	V <sub>CC</sub> = Max, V <sub>INB</sub> = V <sub>CC</sub>		180	450	μΑ
I <sub>ILB</sub>	Logical "0" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V			-40	μΑ
V <sub>OLB</sub>	Logical "0" Output Voltage	V <sub>CC</sub> = Min, I <sub>OUT</sub> = 100 mA		0.4	0.8	V
loL	Logical "0" Output Current	V <sub>CC</sub> = Min, V <sub>OL</sub> = 0.8V	100			mA
Іонв	Power "OFF" Bus Current	V <sub>CC</sub> = 0V, V <sub>INB</sub> = 5.25V		1.7	2.65	mA
RECEIV	ER OUTPUT			•		
V <sub>OH</sub>	Logical "1" Output Voltage	V <sub>CC</sub> = Min, I <sub>OUT</sub> = -1 mA	2.4	3.2		V
Іон	Logical "1" Output Current	V <sub>CC</sub> = Min, V <sub>OUT</sub> = 5.5V			100	μΑ
Ios	Output Short Circuit Current	V <sub>CC</sub> = Min, V <sub>OUT</sub> = 0V, (Note 4)		-28	-55	mA
V <sub>OL</sub>	Logical "0" Output Voltage	V <sub>CC</sub> = Min, I <sub>OUT</sub> = 16 mA		0.3	0.45	V
Icc	Supply Current	V <sub>CC</sub> = Max		49	64	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8642. All typicals are given for  $V_{CC} = 5V$  and  $T_{A} = 25^{\circ}$ C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

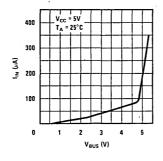
<sup>\*</sup>Derate cavity package 9.6 mW/ $^{\circ}C$  above 25  $^{\circ}C$ ; derate molded package 10.9 mW/ $^{\circ}C$  above 25  $^{\circ}C$ .

### **Switching Characteristics** T<sub>A</sub> = 25°C, nominal power supplies unless otherwise noted

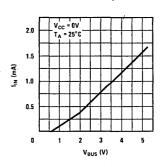
	PARAMETER	CONDITIONS	MIN	ТҮР	MAX	UNITS
t <sub>pd0</sub>	Propagation Delay to a Logical "0" From Data Input to Receiver Output	(Figure 1)		34	50	ns
t <sub>pd1</sub>	Propagation Delay to a Logical "1" From Data Input to Receiver Output	(Figure 1)		25	50	ns
t <sub>pd0</sub>	Propagation Delay to a Logical "0" From Strobe Input to Receiver Output	(Figure 1)		38	55	ns
t <sub>pd1</sub>	Propagation Delay to a Logical "1" From Strobe Input to Receiver Output	(Figure 1)		25	55	ns

### **Typical Performance Characteristics**

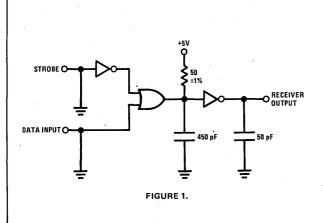
Receiver ON Impedance

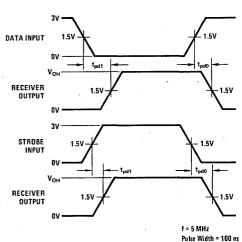


Receiver OFF Impedance



### **AC Test Circuit and Switching Time Waveforms**





### **9**



### **Bus Transceivers**

### DS7833/DS8833, DS7835/DS8835 Quad TRI-STATE® Bus Transceivers

### **General Description**

This family of TRI-STATE bus transceivers offer extreme versatility in bus organized data transmission systems. The data bus may be unterminated, or terminated dc or ac, at one or both ends. Drivers in the third (high impedance) state load the data bus with a negligible leakage current. The receiver input current is low allowing at least 100 driver/receiver pairs to utilize a single bus. The bus loading is unchanged when  $V_{CC} = 0V$ . The receiver incorporates hysteresis to provide greater noise immunity. All devices utilize a high current TRI-STATE output driver. The DS7833/DS8833 and DS7835/DS8835 employ TRI-STATE outputs on the receiver also.

The DS7833/DS8833 are non-inverting quad transceivers with a common inverter driver disable control and a common inverter receiver disable control.

The DS7835/DS8835 are inverting quad transceivers with a common inverter driver disable control and a common inverter receiver disable control.

#### **Features**

■ Receiver hysteresis

400 mV typ

■ Receiver noise immunity

1.4V typ

 Bus terminal current for normal V<sub>CC</sub> or V<sub>CC</sub> = 0V 80µA max

■ Receivers

Sink Source 16 mA at 0.4V max 2.0 mA (MiI) at 2.4V min

5.2 mA (Com) at 2.4V min

Drivers

Sink

50 mA at 0.5V max 32 mA at 0.4V max

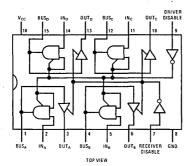
Source

10.4 mA (Com) at 2.4V min 5.2 mA (Mil) at 2.4V min

- Drivers have TRI-STATE outputs
- DS7833/DS8833, DS7835/DS8835 receivers have TRI-STATE outputs
- Capable of driving 100Ω dc-terminated buses
- Compatible with Series 54/74

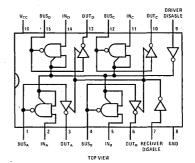
### **Connection Diagrams**

#### Dual-In-Line Package



Order Number DS7833J, DS8833J or DS8833N See NS Package J16A or N16A

#### Dual-In-Line Package



Order Number DS7835J, DS8835J or DS8835N See NS Package J16A or N16A

### Absolute Maximum Ratings (Note 1) .Operating Conditions

			MIN	MAX	UNITS
Supply Voltage	7.0V	Supply Voltage (VCC)			
Input Voltage	5.5V	DS7833, DS7835	4.5	5.5	V
Output Voltage	5.5V	DS8833, DS8835	4.75	5.25	V
Storage Temperature Maximum Power Dissipation* at 25	–65°C to +150°C °C	Temperature (T <sub>A</sub> ) DS7833, DS7835	-55	+125	°c
Cavity Package Molded Package	1509 mW 1476 mW	DS8833, DS8835	0	+70	°C
Lead Temperature (Soldering, 10 se	conds) 300°C				

<sup>\*</sup>Derate cavity package 10.1 mW/°C above 25°C; derate molded package 11.8 mW/°C above 25°C.

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS
DISABL	E/DRIVER INPUT							
V <sub>IH</sub>	High Level Input Voltage	V <sub>CC</sub> = Min			2.0			V
VIL	Low Level Input Voltage	V <sub>CC</sub> = Min	DS7833, DS8833,	DS8835			0.8	V
				DS7835			0.7	
t <sub>iH</sub>	High Level Input Current	V <sub>CC</sub> = Max	V <sub>IN</sub> = 2.4V				40	μΑ
	· ·	VCC	V <sub>IN</sub> = 5.5V				1,0	mA
l <sub>IL</sub>	Low Level Input Current	$V_{CC} = Max, V_{IN} = 0.$	4V			-1.0	-1.6	mA
V <sub>CL</sub>	Input Clamp Diode	V <sub>CC</sub> = 5.0V, I <sub>IN</sub> = -1	12 mA, T <sub>A</sub> = 25°C			-0.8	-1,5	>
. I <sub>IT</sub>	Driver Low Level Disabled Input Current	Driver Disable Input =	= 2.0V, V <sub>IN</sub> = 0.4V				-40	μΑ
RECEIV	ER INPUT/BUS OUTPUT							
V <sub>TH</sub>	High Level Threshold Voltage		DS7833, DS7835		1.4	1.75	2,1	·v
	,	1	DS8833, DS8835		1.5	1.75	2.0	V
V <sub>TL</sub>	Low Level Threshold Voltage			DS7833, DS7835	0.8	1.35	1.6	V
			•	DS8833, DS8835	0.8	1.35	1.5	V
I <sub>B</sub>	I <sub>B</sub> Bus Current, Output Disabled	V <sub>BUS</sub> = 4.0V	V <sub>CC</sub> = Max			25	80	μА
or High	or High		V <sub>cc</sub> = 0V			5.0	80	μΑ
		V <sub>CC</sub> = Max, V <sub>BUS</sub> = (	0.4V			-2.0	-40	μΑ
VoH	Logic "1" Output Voltage	V <sub>CC</sub> = Min	I <sub>OUT</sub> = −5.2 mA	DS7833, DS7835	2.4	2.75		V
		V GC WIII	I <sub>OUT</sub> = -10.4 mA	DS8833, DS8835	2.4	2.75		V
VoL	Logic "0" Output Voltage	V <sub>CC</sub> ≖ Min	I <sub>OUT</sub> = 50 mA			0.28	0.5	V
		VCC IIIII	I <sub>OUT</sub> = 32 mA				0.4	V
los	Output Short Circuit Current	V <sub>CC</sub> = Max, (Note 4)			-40	-62	-120	mA
RECEIVE	ER OUTPUT						. •	
VoH	Logic "1" Output Voltage		I <sub>OUT</sub> = -2.0 mA	DS7833, DS7835	2.4	3.0	1	V
		V <sub>cc</sub> = Min	I <sub>OUT</sub> = -5.2 mA	DS8833, DS8835	2.4	2.9		V
VoL	Logic "0" Output Voltage	V <sub>CC</sub> = Min, I <sub>OUT</sub> = 1	6 mA			0.22	0.4	>
I <sub>OT</sub>	Output Disabled Current	V <sub>CC</sub> = Max, Disable	V <sub>OUT</sub> = 2.4V				40	μА
		Inputs = 2.0V	V <sub>DUT</sub> = 0.4V				<del>-4</del> 0	μA
los	Output Short Circuit Current	V <sub>CC</sub> = Max, (Note 4)		DS7833, DS7835	-28	-40	-70	mA
		ACC - MINTY, (MOTE 4)		DS8833, DS8835	-30		-70	mA
Icc	Supply Current	V = May		DS7833/DS8833		84	116	mA
		V <sub>CC</sub> = Max		DS7835/DS8835		75	95	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS7833, DS7835 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8833, DS8835. All typicals are given for  $V_{CC} = 5.0V$  and  $T_{A} = 25^{\circ}$ C. Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

### Switching Characteristics $V_{CC} = 5.0V$ , $T_A = 25^{\circ}C$

	PARAMETER	CONDITIONS	3	MIN	TYP	MAX	UNIT
t <sub>pd0</sub>	Propagation Delay to a Logic "0" From Input to Bus	(Figure 1)	DS7833/DS8833 DS7835/DS8835		14 10	· 30	ns ns
t <sub>pd1</sub>	Propagation Delay to a Logic "1" From Input to Bus	(Figure 1)	DS7833/DS8833 DS7835/DS8835		14	30 30	ns
t <sub>pd0</sub>	Propagation Delay to a Logic "0" From Bus to Output	(Figure 2)	DS7833/DS8833 DS7835/DS8835		24 16	45 35	ns ns
t <sub>pd1</sub>	Propagation Delay to a Logic "1" From Bus to Output	(Figure 2)	DS7833/DS8833 DS7835/DS8835		12 18	30 30	ns
<sup>†</sup> PHZ	Delay From Disable Input to High Impedance State (From Logic "1" Level)	C <sub>L</sub> = 5.0 pF, (Figures 1 and 2)	Driver Receiver		8.0 6.0	20 15	ns ns
tPLZ	Delay From Disable Input to High Impedance State (From Logic "O" Level)	C <sub>L</sub> = 5.0 pF, (Figures 1 and 2)	Driver Receiver		20 13	35 25	ns
<sup>†</sup> PZH	Delay From Disable Input to Logic "1" Level (From High Impedance State)	C <sub>L</sub> = 50 pF, (Figures 1 and 2)	Driver Receiver		24 16	40 35	ns
tPZL <u>,</u>	Delay From Disable Input to Logic "O" Level (From High	C <sub>L</sub> = 50 pF, (Figures 1 and 2)	Driver Receiver DS7833/DS8833		19 15	35 30	ns
	Impedance State)		Receiver DS7835/DS8835		33	50	ns

### **AC Test Circuits**

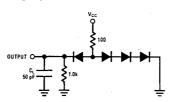


FIGURE 1. Driver Output Load

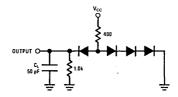
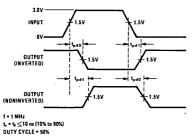


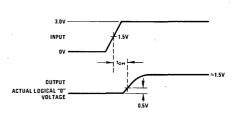
FIGURE 2. Receiver Output Load

### **Switching Time Waveforms**

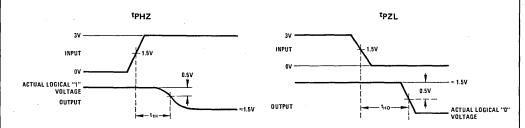
tpd1 & tpd0

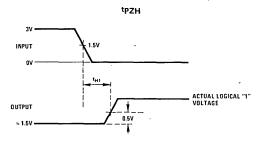


<sup>t</sup>PLZ



### Switching Time Waveforms (Continued)





### DS7834/DS8834, DS7839/DS8839 Quad TRI-STATÉ® Bus Transceivers

### General Description

This family of TRI-STATE bus transceivers offers extreme versatility in bus organized data transmission systems. The data bus may be unterminated, or terminated dc or ac, at one or both ends. Drivers in the third (high impedance) state load the data bus with a negligible leakage current. The receiver input current is low, allowing at least 100 driver/receiver pairs to utilize a single bus. The bus loading is unchanged when V<sub>CC</sub> = 0V. The receiver incorporates hysteresis to provide greater noise immunity. Both devices utilize a high current TRI-STATE output driver. The DS7834/ DS8834 and DS7839/DS8839 employ TTL outputs on the receiver.

The DS7839/DS8839 are non-inverting guad transceivers with two common inverter driver disable controls.

The DS7834/DS8834 are inverting quad transceivers with two common inverter driver disable controls.

### **Features**

Receiver hysteresis

400 mV typ

Receiver noise immunity

1.4V typ

Bus terminal current for normal V<sub>CC</sub> or V<sub>CC</sub> = 0V 80µA max

Receivers

Sink Source

16 mA at 0.4V max 2.0 mA (Mil) at 2.4V min

**Bus Transceivers** 

5.2 mA (Com) at 2.4V min

Drivers

Sink

50 mA at 0.5V max

Source

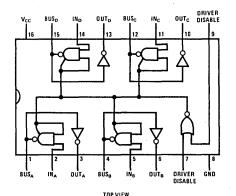
32 mA at 0.4V max 10.4 mA (Com) at 2.4V min

5.2 mA (Mil) at 2.4V min

- Drivers have TRI-STATE outputs
- Receivers have TRI-STATE outputs
- Capable of driving 100Ω dc—terminated buses
- Compatible with Series 54/74

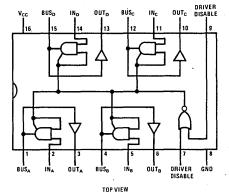
### **Connection Diagrams**

#### Dual-In-Line Package



Order Number DS7834J, DS8834J or DS8834N See NS Package J16A or N16A

#### Dual-In-Line Package



Order Number DS7839J, DS8839J

or DS8839N See NS Package J16A or N16A

<b>Absolute Maximum Ratio</b>	ngs (Note 1)	<b>Operating Condit</b>	ions		
	•		MIN	MAX	UNITS
Supply Voltage	7.0V	Supply Voltage (V <sub>CC</sub> )			
Input Voltage	5.5V	DS7834, DS7839	4.5	5.5	٧
Output Voltage	5.5V	DS8834, DS8839	4.75	5.25	V
Storage Temperature  Maximum Power Dissipation* at 25°C  Cavity Package	–65°C to +150°C	Temperature (T <sub>A</sub> ) DS7834, DS7839	-55	+125	°C
Molded Package Lead Temperature (Soldering, 10 Seconds)	1476 mW 300°C	DS8834, DS8839	0	+70	°C
*Derate cavity package 10.1 mW/°C above 2 package 11.8 mW/°C above 25°C.	5°C; derate molded				

### Electrical Characteristics (Notes 2 and 3)

	PARAMETER	<u></u>	CONDITIONS		MIN	TYP	MAX	UNITS
DISABLE	DRIVER INPUT							
V <sub>IH</sub>	High Level Input Voltage	V <sub>CC</sub> = Min .		· · · · · · · · · · · · · · · · · · ·	2.0			V
V <sub>IL</sub>	Low Level Input Voltage	V <sub>CC</sub> = Min					0.8	V
I <sub>IH</sub>	High Level Input Current	V <sub>CC</sub> = Max	V <sub>IN</sub> = 2.4V				40	μΑ
		V <sub>CC</sub> = Max	$V_{IN} = 2.4V$ $V_{IN} = 5.5V$				1.0	mA
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max, V	<sub>IN</sub> = 0.4V			-1.0	-1.6	mA
I <sub>IND</sub>	Driver Disabled Input Low Current	Driver Disable	Input = 2.0V, V <sub>IN</sub> = 0	4V		;	-40	μА
V <sub>CL</sub>	Input Clamp Diode	V <sub>CC</sub> = 5.0V, 1	$V_{CC} = 5.0V$ , $I_{IN} = -12 \text{ mA}$ , $T_A = 25^{\circ}\text{C}$			-0.8	-1.5	V
RECEIVE	R INPUT/BUS OUTPUT							
V <sub>TH</sub>	High Level Threshold Voltage			DS7834, DS7839	1.4	1.75	2.1	V
		V <sub>CC</sub> = Max		DS8834, DS8839	1.5	1.75	2.0	٧
V <sub>TL</sub>	Low Level Threshold Voltage	)/ - Mi-		DS7834, DS7839	0.8	1.35	1.6	V
		V <sub>CC</sub> = Min		DS8834, DS8839	0.8	1.35	1.5	٧
I <sub>BH</sub>	Bus Current, Output Disabled or High	V <sub>BUS</sub> = 4.0V	V <sub>CC</sub> = Max, V <sub>BUS</sub> = 4.0V Disable Input = 2.0V			25	80	μΑ
	•		V <sub>CC</sub> = 0V			5.0	80	μΑ
		V <sub>CC</sub> = Max, V	BUS = 0.4V, Disable I	nput = 2.0V		L	-40	μΔ
$V_{OH}$	Logic "1" Output Voltage	V <sub>CC</sub> = Min	I <sub>OUT</sub> = -5.2 mA	DS7834, DS7839	2.4	2.75		V
		1	I <sub>OUT</sub> = -10.4 mA	DS7834, DS8839	2.4	2.75	İ	٧
$V_{OL}$	Logic "0" Output Voltage	V <sub>CC</sub> = Min	I <sub>OUT</sub> = 50 mA			0.28	0.5	V
			I <sub>OUT</sub> = 32 mA				0.4	V
los	Output Short Circuit Current	V <sub>CC</sub> = Max, (I	Note 4)		-40	-62	-120	mA
RECEIVE	ER OUTPUT			_				
$V_{OH}$	Logic "1" Output Voltage	V <sub>CC</sub> = Min	I <sub>OUT</sub> = -2.0 mA	DS7834, DS7839	2.4	3.0		\ \\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\
			I <sub>OUT</sub> = -5.2 mA	DS8834, DS8839	2.4	2.9		V
VoL	Logic "0" Output Voltage	V <sub>CC</sub> = Min, I <sub>C</sub>	<sub>DUT</sub> = 16 mA			0.22	0.4	
Ios	Output Short Circuit Current	V <sub>CC</sub> = Max, (	Note 4)	DS7834, DS7839	-28	-40	-70	m/
				DS8834, DS8839	-30	ļ	-70	m A
Icc	Supply Current	V <sub>CC</sub> = Max				. 75	95	m/

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS7834, DS7839 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8834, DS8839. All typicals are given for  $V_{CC} = 5.0V$  and  $T_{A} = 25^{\circ}$ C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

### Switching Characteristics $v_{cc} = 5.0V$ , $T_A = 25^{\circ}C$

	PARAMETER	CONDITIONS	3	MIN	TYP	MAX	UNITS
t <sub>pd0</sub>	Propagation Delay to a Logic "0" from Input to Bus	(Figure 1)	DS7839/DS8839 DS7834/DS8834		14	30	ns ns
t <sub>pd 1</sub>	Propagation Delay to a Logic "1"	(Figure 1)	DS7839/DS8839		14	30	ns
t <sub>pd</sub> 0	from Input to Bus  Propagation Delay to a Logic "0"  from Bus to Output	(Figure 2)	DS7834/DS8834  DS7839/DS8839  DS7834/DS8834		11 24 16	30 45 35	ns ns
t <sub>pd1</sub>	Propagation Delay to a Logic "1" from Bus to Output	(Figure 2)	DS7839/DS8839 DS7834/DS8834	-	12	30	ns ns
tPHZ	Delay from Disable Input to High Impedance State (from Logic "1" Level)	C <sub>L</sub> = 5.0 pF, (Figures 1 and 2)	Driver Only		8	20	ns
tPLZ	Delay from Disable Input to High Impedance State (from Logic "0" Level)	C <sub>L</sub> = 5.0 pF, (Figures 1 and 2)	Driver Only	1	20	35	ns
<sup>t</sup> PZH	Delay from Disable Input to Logic "1" Level (from High Impedance State)	$C_L = 50 \text{ pF}$ , (Figures 1 and 2)	Driver Only		24	40	ns
tPZL	Delay from Disable Input to Logic "0" Level (from High Impedance State)	C <sub>L</sub> = 50 pF, (Figures 1 and 2)	Driver Only		19	35	ns

### **AC Test Circuit**

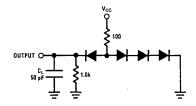


FIGURE 1. Driver Output Load

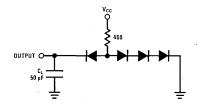
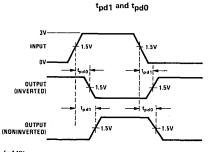
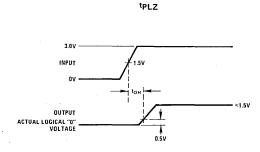


FIGURE 2. Receiver Output Load

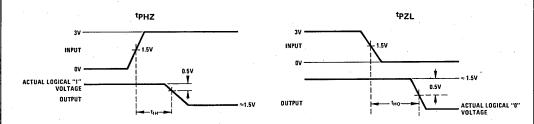
### **Switching Time Waveforms**

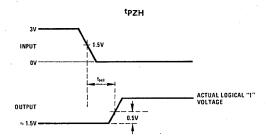


t = 1 MHz t, = t<sub>f</sub> ≤ 10 ns (10% to 90%) Duty Cycle = 50%



### Switching Time Waveforms (Continued)





### **Truth Table**

DISABLE INPUT	DRIVER INPUT (IN <sub>X</sub> )	RECEIVER INPUT/ BUS OUTPUT (BUS <sub>X</sub> )	RECEIVER OUTPUT (OUT <sub>x</sub> )	MODE OF OPERATION					
DS7834/DS8	DS7834/DS8834								
1	X		BUS	Receive bus signal					
0	1	0 .	1 -	Drive bus					
0	0	1	0	Drive bus					
DS7839/DS8	839								
1	Х		BUS	Receive bus signal					
0	1	1	1	Drive bus					
0	0	0	, 0	Drive bus					

X = Don't care



### DS7836/DS8836 Quad NOR Unified Bus Receiver

### General Description

The DS7836/DS8836 are quad 2-input receivers designed for use in bus organized data transmission systems interconnected by terminated 120 $\Omega$  impedance lines. The external termination is intended to be  $180\Omega$  resistor from the bus to the +5V logic supply together with a 390 $\Omega$  resistor from the bus to ground. The design employs a built-in input hysteresis providing substantial noise immunity. Low input current allows up to 27 driver/ receiver pairs to utilize a common bus. Performance is optimized for systems with bus rise and fall times  $\leq 1.0 \,\mu\text{s/V}$ .

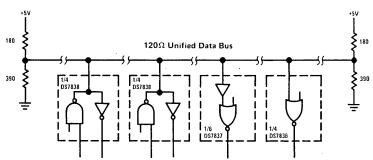
### **Features**

■ Low input current with normal V<sub>CC</sub> or  $V_{CC} = 0V (15 \mu A \text{ typ})$ 

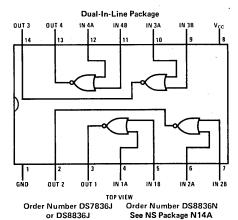
**Bus Transceivers** 

- Built-in input hysteresis (1V typ)
- High noise immunity (2V typ)
- Temperature-insensitive input thresholds track bus logic levels
- TTL compatible output
- Matched, optimized noise immunity for "1" and "O" levels
- High speed (18 ns typ)

### Typical Application



### **Connection Diagram**



See NS Package J14A 2-83

### **Absolute Maximum Ratings**

### **Operating Conditions**

			MIN	MAX	UNITS
Supply Voltage	7.0V	Supply Voltage (VCC)			
Current Voltage		DS7836	4.5	5.5	V
Storage Temperature Range	-65°C to +150°C	DS8836	4.75	5.25	٧
Maximum Power Dissipation* at 25°C Cavity Package Molded Package Lead Temperature (Soldering, 10 seconds)	1308 mW 1207 mW 300°C	Temperature (T <sub>A</sub> ) DS7836 DS8836	–55 0	+125 +70	°c °c

<sup>\*</sup>Derate cavity package 8.7 mW/°C above 25°C; derate molded package 9.7 mW/°C above 25°C.

#### **Electrical Characteristics**

The following apply for  $V_{MIN} \le V_{CC} \le V_{MAX}$ ,  $T_{MIN} \le T_A \le T_{MAX}$ , unless otherwise specified (Notes 2 and 3)

	PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS
V <sub>TH</sub> High Level Input Threshold		V <sub>CC</sub> = Max	V - Max DS7836		1.65	2.25	2.65	V
		4.CC 1410V		DS8836	1.80	2.25	2.50	V
V <sub>IL</sub>	Low Level Input Threshold	\/ - Mi-		DS7836	0.97	1.30	1.63	· V
		V <sub>CC</sub> = Min		DS8836	1.05	1.30	1.55	٧
I <sub>IN</sub>	Maximum Input Current	V <sub>IN</sub> = 4V	V <sub>CC</sub> = Max			15	50	μА
,		V <sub>IN</sub> = 4V V <sub>CC</sub> = 0V				1	50	μΑ
VoH	Logical "1" Output Voltage	$V_{IN} = 0.5V$ , $I_{OUT} = -400\mu A$		2.4			V	
VoL	Logical "0" Output Voltage	V <sub>IN</sub> = 4V, !	V <sub>IN</sub> = 4V, I <sub>OUT</sub> = 16 mA			0.25	0.4	V
I <sub>sc</sub>	Output Short Circuit Current	V <sub>IN</sub> = 0.5V	V <sub>IN</sub> = 0.5V, V <sub>OUT</sub> = 0V, V <sub>CC</sub> = Max, (Note 4)		18		-55	mA
Icc	Power Supply Current	V <sub>IN</sub> = 4V, (Per Package)			25	40	mA	
V <sub>CL</sub>	Input Clamp Diode Voltage	1 <sub>IN</sub> = -12 m	nA, T <sub>A</sub> = 25°C			-1	-1.5	

### **Switching Characteristics**

V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C unless otherwise specified.

PARAMETER		C	ONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd</sub>	Propagation Delays	(Natos 4 and E)	Input to Logical "1" Output		20	30	ns
		(Notes 4 and 5)	Input to Logical "0" Output		18	30	ns ,

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS7836 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8836. All typical values are for T<sub>A</sub> =  $25^{\circ}$ C and V<sub>CC</sub> = 5V.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Fan-out of 10 load, C<sub>LOAD</sub> = 15 pF total, measured from V<sub>IN</sub> = 1.3V to V<sub>OUT</sub> = 1.5V, V<sub>IN</sub> = 0V to 3V pulse.

Note 5: Fan-out of 10 load,  $C_{LOAD}$  = 15 pF total, measured from  $V_{IN}$  = 2.3V to  $V_{OUT}$  = 1.5V,  $V_{IN}$  = 0V to 3V pulse.



### **Bus Transceivers**

### DS7837/DS8837 Hex Unified Bus Receiver

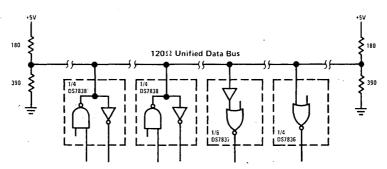
### **General Description**

The DS7837/DS8837 are high speed receivers designed for use in bus organized data transmission systems interconnected by terminated 120 $\Omega$  impedance lines. The external termination is intended to be 180 $\Omega$  resistor from the bus to the +5V logic supply together with a 390 $\Omega$  resistor from the bus to ground. The receiver design employs a built-in input hysteresis providing substantial noise immunity. Low input current allows up to 27 driver/receiver pairs to utilize a common bus. Disable inputs provide time discrimination. Disable inputs and receiver outputs are TTL compatible. Performance is optimized for systems with bus rise and fall times  $\leq$  1.0  $\mu$ s/V.

#### **Features**

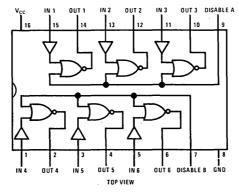
- Low receiver input current for normal V<sub>CC</sub> or V<sub>CC</sub> = 0V (15 µA typ)
- Six separate receivers per package
- Built-in receiver input hysteresis (1V typ)
- High receiver noise immunity (2V typ)
- Temperature insensitive receiver input thresholds track bus logic levels
- TTL compatible disable and output
- Molded or cavity dual-in-line or flat package
- High speed

### **Typical Application**



### **Connection Diagram**

#### Dual-In-Line Package



Order Number DS7837J or DS8837J See NS Package J16A Order Number DS8837N See NS Package N16A

#### **Absolute Maximum Ratings Operating Conditions** UNITS MIN MAX Supply Voltage (VCC) Supply Voltage 7V Input Voltage 5.5V DS7837 4.5 5.5 Operating Temperature Range DS8837 4.75 5.25 DS7837 -55°C to +125°C Temperature (TA) DS8837 0°C to +70°C °C DS7837 -55 +125 -65°C to +150°C Storage Temperature Range DS8837 0 +70 Maximum Power Dissipation\* at 25°C Cavity Package 1433 mW Molded Package 1362 mW Lead Temperature (Soldering, 10 seconds) 300°C \*Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.9 mW/°C above 25°C.

#### **Electrical Characteristics**

The following apply for  $V_{MIN} \le V_{CC} \le V_{MAX}$ ,  $T_{MIN} \le T_A \le T_{MAX}$ , unless otherwise specified (Notes 2 and 3)

	PARAMETER	CONDIT	TIONS	MIN	TYP	MAX	UNITS
V <sub>TH</sub>	High Level Receiver Threshold		DS7837	1.65	2.25	2.65	V
		V <sub>CC</sub> = Max	DS8837	1.80	2.25	2.50	V
V <sub>TL</sub>	Low Level Receiver Threshold		DS7837	0.97	1.30	1.63	٧
	·	V <sub>CC</sub> = Min	DS8837	1.05	1.30	1.55	V
I <sub>IH</sub>	Maximum Receiver Input Current	V <sub>IN</sub> = 4V	V <sub>CC</sub> = V <sub>MAX</sub>		15.0	50.0	μΑ
		VIN - 4V ,	V <sub>CC</sub> = 0V		1.0	50.0	μΑ
I <sub>IL</sub>	Logical "0" Receiver Input Current	$V_{IN} = 0.4V$ , $V_{CC} = V_{MAX}$			1.0	50.0	μΑ
V <sub>1H</sub>	Logical "1" Input Voltage		Disable	2.0			V
V <sub>IL</sub>	Logical "0" Input Voltage		Disable			0.8	٧
I <sub>IH</sub>	Logical "1" Input Current	Disable Input	V <sub>IND</sub> = 2.4V			80.0	μΑ
		Disable Input	V <sub>IND</sub> = 5.5V			2.0	mA
IIL	Logical "0" Input Current	V <sub>IN</sub> = 4V, V <sub>IND</sub> = 0.4V, Disa	ble Input			-3.2	mA
V <sub>oH</sub>	Logical "1" Output Voltage	$V_{1N} = 0.5V, V_{1ND} = 0.8V, I_{O}$	н = -400µA	2.4	,		٧
VoL	Logical "0" Output Voltage	V <sub>IN</sub> = 4V, V <sub>IND</sub> = 0.8V, I <sub>OL</sub>	= 16 mA		0.25	0.4	٧
Ios	Output Short Circuit Current	$V_{1N} = 0.5V$ , $V_{1ND} = 0V$ , $V_{OS} = 0V$ , $V_{CC} = V_{MAX}$ , (Note 4)		-18.0		-55.0	mA
Icc	Power Supply Current	V <sub>IN</sub> = 4V, V <sub>IND</sub> = 0V, (Per Package)			45.0	60.0	mA
V <sub>CL</sub>	Input Clamp Diode	V <sub>IN</sub> = -12 mA, V <sub>IND</sub> = -12 n	nA, T <sub>A</sub> = 25°C		-1.0	-1.5	٧.

### Switching Characteristics T<sub>A</sub> = 25°C, nominal power supplies unless otherwise noted

PARAMETER			CONDITIONS		TYP	MAX	UNITS
t <sub>pd</sub>	Propagation Delays	$V_{IND} = 0V$	Input to Logical "1" Output, (Note 5)		20	30	ns
		Receiver	Input to Logical "O" Output, (Note 6)		18	30	ns
		Input = 0V,	Input to Logical "1" Output		9	15	ns
	•	Disable,	Input to Logical "O" Output		4	10	ns
		(Note 7)			1		

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS7837 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8837. All typicals values are for T<sub>A</sub> =  $25^{\circ}$ C and V<sub>CC</sub> = 5V.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: Fan-out of 10 load,  $C_{LOAD}$  = 15 pF total. Measured from  $V_{IN}$  = 1.3V to  $V_{OUT}$  = 1.5V,  $V_{IN}$  = 0V to 3V pulse.

Note 6: Fan-out of 10 load,  $C_{LOAD}$  =15 pF total. Measured from  $V_{IN}$  = 2.3V to  $V_{OUT}$  = 1.5V,  $V_{IN}$  = 0V to 3V pulse.

Note 7: Fan-out of 10 load,  $C_{LOAD}$  = 15 pF total. Measured from  $V_{IN}$  = 1.5V to  $V_{OUT}$  = 1.5V,  $V_{IN}$  = 0V to 3V pulse.



### DS7838/DS8838 Quad Unified Bus Transceiver

### **General Description**

The DS7838/DS8838 are quad high speed drivers/ receivers designed for use in bus organized data transmission systems interconnected by terminated 120 $\Omega$  impedance lines. The external termination is intended to be a  $180\Omega$  resistor from the bus to the +5V logic supply together with a 390 $\Omega$ resistor from the bus to ground. The bus can be terminated at one or both ends. Low bus pin current allows up to 27 driver/receiver pairs to utilize a common bus. The bus loading is unchanged when  $V_{cc} = 0V$ . The receivers incorporate hysteresis to greatly enhance bus noise immunity. One two-input NOR gate is included to disable all drivers in a package simultaneously. Receiver performance is optimized for systems with bus rise and fall times  $\leq 1.0 \mu s/V$ .

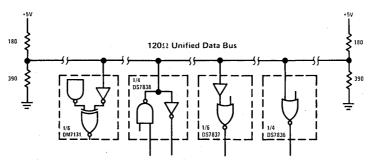
#### **Features**

 4 totally separate driver/receiver pairs per package

**Bus Transceivers** 

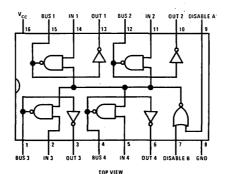
- 1V typical receiver input hysteresis
- Receiver hysteresis independent of receiver output load
- Guaranteed minimum bus noise immunity of 1.3V, 2V typ.
- Temperature-insensitive receiver thresholds track bus logic levels
- 20µA typical bus terminal current with normal  $V_{cc}$  or with  $V_{cc} = 0V$
- Open collector driver output allows wire-OR connection
- High speed
- Series 74 TTL compatible driver and disable inputs and receiver outputs

### Typical Application



### Connection Diagram

Dual-In-Line Package



Order Number DS7838J or DS8838J See NS Package J16A

Order Number DS8838N See NS Package N16A

### Absolute Maximum Ratings (Note 1)

Supply Voltage 7V
Input and Output Voltage 5.5V
Maximum Power Dissipation\* at 25°C

Operating Temperature Range DS7838 DS8838

-55°C to +125°C 0°C to +70°C -65°C to +150°C 300°C

Storage Temperature Range Lead Temperature, (Soldering, 10 sec)

\*Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.9 mW/°C above 25°C.

### **Electrical Characteristics**

Cavity Package Molded Package

DS7838/DS8838: The following apply for  $V_{MIN} \le V_{CC} \le V_{MAX}$ ,  $T_{MIN} \le T_A \le T_{MAX}$  unless otherwise specified (Notes 2 and 3)

1433 mW

1362 mW

PARAMETER		CONDITIONS		MIN	TYP	MAX	UNIT
DRIVER A	ND DISABLE INPUTS		· · · · · · · · · · · · · · · · · · ·				
V <sub>IH</sub> Log	gical "1" Input Voltage			2.0			V
V <sub>IL</sub> Log	gical "0" Input Voltage					0.8	٧
I <sub>1</sub> Log	gical "1" Input Current	V <sub>IN</sub> = 5.5V				1	mA
I <sub>IH</sub> Log	gical "1" Input Current	V <sub>IN</sub> = 2.4V				40	μΑ
I <sub>IL</sub> Log	gical "0" Input Current	V <sub>IN</sub> = 0.4V				-1.6	mΑ
V <sub>CL</sub> Inp	out Diode Clamp Voltage	$I_{DIS} = -12 \text{ mA}, I_{IN} = -12 \text{ mA}, I_{B}$ $T_{A} = 25^{\circ}\text{C}$		-1	-1.5	٧	
DRIVER O	UTPUT/RECEIVER INPUT						
V <sub>OLB</sub> Lo	w Level Bus Voltage	V <sub>DIS</sub> = 0.8V, V <sub>IN</sub> = 2V, I <sub>BUS</sub> = 50 mA			0.4	0.7	\
І <sub>ІНВ</sub> Ма	ximum Bus Current	V <sub>IN</sub> = 0.8V, V <sub>BUS</sub> = 4V, V <sub>CC</sub> = V <sub>MAX</sub>			20	100	μA
I <sub>ILB</sub> Ma	ximum Bus Current	$V_{IN} = 0.8V, V_{BUS} = 4V, V_{CC} = 0V$			2	100	μΑ
V <sub>IH</sub> Hig	gh Level Receiver Threshold	V <sub>IND</sub> 0.8V, V <sub>OL</sub> = 16 mA	DS7838	1.65	2.25	2.65	\
		V <sub>CC</sub> = Max	DS8838	1.80	2.25	2.50	~
V <sub>IL</sub> Lo	w Level Receiver Threshold	$V_{IND} = 0.8V, V_{OH} = -400\mu A$	DS7838	0.97	1.30	1.63	\
		V <sub>cc</sub> = Min	DS8838	1.05	1.30	1.55	· ·
RECEIVER	OUTPUT						
V <sub>OH</sub> . Lo	gical "1" Output Voltage	V <sub>IN</sub> = 0.8V, V <sub>BUS</sub> = 0.5V, I <sub>OH</sub> =	−400µA	2.4			\
V <sub>OL</sub> Lo	gical "0" Output Voltage	V <sub>IN</sub> = 0.8V, V <sub>BUS</sub> = 4V, I <sub>OL</sub> = 1	6 mA		0.25	0.4	\
I <sub>os</sub> Ou	tput Short Circuit Current	$V_{DIS} = 0.8V, V_{IN} = 0.8V, V_{BUS}$ $V_{OS} = 0V, V_{CC} = V_{MAX}, (Note 4)$		-18		-55	m.
I <sub>CC</sub> Su	pply Current	V <sub>DIS</sub> = 0V, V <sub>IN</sub> = 2V, (Per Package)		_	50	70	m/
t <sub>pd</sub> Pro	opagation Delays (Note 8)						
	Disable to Bus "1"	(Note 5)			19	30	n
	Disable to Bus "0"	(Note 5)			15	23	n
· · · · · · · · · · · · · · · · · · ·	Driver Input to Bus "1"	(Note 5)			17	25	n
	Driver Input to Bus "0"	(Note 5)			9	15	n
	Bus to Logical "1" Reciever Output	(Note 6)		ļ	20	30	n
	Bus to Logical "0" Receiver Output	(Note 7)			18	30	l n

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS7838 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8838. All typical values are for  $T_{A} = 25^{\circ}$ C and  $V_{CC} = 5V$ .

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: 91 $\Omega$  from bus pin to  $V_{CC}$  and 200 $\Omega$  from bus pin to ground,  $C_{LOAD}$  = 15 pF total. Measured from  $V_{IN}$  = 1.5V to  $V_{BUS}$  = 1.5V,  $V_{IN}$  = 0V to 3.0V pulse.

Note 6: Fan-out of 10 load, CLOAD = 15 pF total. Measured from VIN = 1.3V to VOUT = 1.5V, VIN = 0V to 3.0V pulse.

Note 7: Fan-out of 10 load,  $C_{LOAD}$  = 15 pF total. Measured from  $V_{IN}$  = 2.3V to  $V_{OUT}$  = 1.5V  $\dot{V}_{IN}$  = 0V to 3.0V pulse.

Note 8: These apply for V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C unless otherwise specified.



### DS8T26A, DS8T26AM, DS8T28, DS8T28M 4-Bit Bidirectional Bus Transceivers

### **General Description**

The DS8T26A, DS8T28 consist of 4 pairs of TRI-STATE® logic elements configured as quad bus drivers/ receivers along with separate buffered receiver enable and driver enable lines. This single IC quad transceiver design distinguishes the DS8T26A, DS8T28 from conventional multi-IC implementations. In addition, the DS8T26A, DS8T28's ultra high speed while driving heavy bus capacitance (300 pF) makes these devices particularly suitable for memory systems and bidirectional data buses.

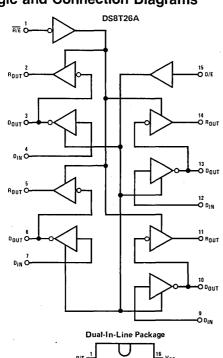
Both the driver and receiver gates have TRI-STATE outputs and low current PNP inputs. PNP inputs reduce input loading to 200  $\mu$ A maximum.

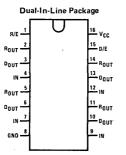
### **Bus Transceivers**

#### **Features**

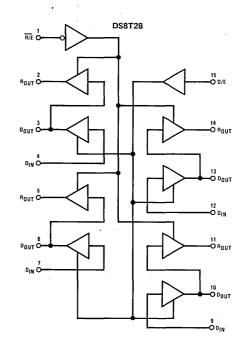
- Inverting outputs in the DS8T26A
- Non-inverting outputs in the DS8T28
  - TRI-STATE outputs
- Low current PNP inputs
- Fast switching times (20 ns)
- Advanced Schottky processing
- Driver glitch free power up/down
- Non-overlapping TRI-STATE

### **Logic and Connection Diagrams**





TOP VIEW



Order Number DS8T26AJ, DS8T26AMJ, DS8T28J, DS8T28MJ, DS8T26AN or DS8T28N See NS Package J16A or N16A

#### Absolute Maximum Ratings (Note 1) **Recommended Operating Conditions** MIN MAX UNITS All Output and Supply Voltages -0.5V to +7V Supply Voltage (VCC) All Input Voltages -1V to +5.5V DS8T26A, DS8T28 4.75 5.25 v **Output Currents** ±150 mA DS8T26AM, DS8T28M ٧ 4.5 5.5 Storage Temperature -65°C to +150°C Temperature (TA) Maximum Power Dissipation\* at 25°C DS8T26A, DS8T28 70 °c Cavity Package 1509 mW °c DS8T26AM, DS8T28M -55 +125 Molded Package 1476 mW Lead Temperature (Soldering, 10 seconds) 300°C \*Derate cavity package 10.1 mW/°C above 25°C; derate molded package 11.8 mW/°C above 25°C.

### Electrical Characteristics (Notes 2, 3 and 4)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
DRIVE	R					<del></del>
Iμ	Low Level Input Current	V <sub>IN</sub> = 0.4V			-200	μΑ
IIL	Low Level Input Current (Disabled)	V <sub>IN</sub> = 0.4V			-25	μΑ
IIH	High Level Input Current (DIN, DE)	VIN = VCC Max			25	μΑ
VOL	Low Level Output Voltage, (Pins 3, 6, 10, 13)	I <sub>OUT</sub> = 48 mA			0.5	V
Voн	High Level Output Voltage, (Pins 3, 6, 10, 13)	I <sub>OUT</sub> =10 mA	2.4			٧
los	Short-Circuit Output Current, (Pins 3, 6, 10, 13)	V <sub>OUT</sub> = 0V, V <sub>CC</sub> = V <sub>CC</sub> Max	-50		-150	mA
RECEIN	/ER					
IIL ·	Low Level Input Current	V <sub>IN</sub> = 0.4V			-200	μА
ΊΗ	High Level Input Current (RE)	VIN = VCC Max			25	μΑ
VOL	Low Level Output Voltage	IOUT = 20 mA			0.5	V
Voн	High Level Output Voltage,	I <sub>OUT</sub> = -100 μA	3.5			V
	(Pins 2, 5, 11, 14)	I <sub>OUT</sub> = -2 mA	2.4			V
los	Short-Circuit Output Current, (Pins 2, 5, 11, 14)	V <sub>OUT</sub> = 0V, V <sub>CC</sub> = V <sub>CC</sub> Max	-30	:	<b>−75</b>	m <sub>i</sub> A
вотн с	DRIVER AND RECEIVER					
VTL	Low Level Input Threshold Voltage	V <sub>CC</sub> = Min, V <sub>IN</sub> = 0.8V, I <sub>OL</sub> = Max	0.85			V
VTH	High Level Input Threshold Voltage	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.8V, I <sub>OH</sub> = Max			2	٧
loz	Low Level Output OFF Leakage Current	V <sub>OUT</sub> = 0.5V			-100	μΑ
loz	High Level Output OFF Leakage Current	V <sub>OUT</sub> = 2.4V			100	μΑ
V <sub>I</sub>	Input Clamp Voltage	I <sub>IN</sub> = -12 mA			-1.0	V
Icc	Power Supply Current DS8T26A	VCC = VCC Max			87	mA
	DST28	VCC = VCC Max			110	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS8T26AM, DS8T28M and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8T26A, DS8T28. All typicals are given for  $V_{CC} = 5V$  and  $T_{A} = 25^{\circ}$ C.

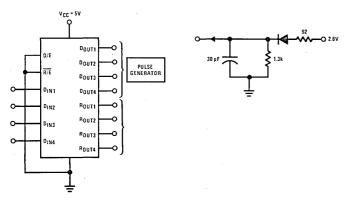
Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise

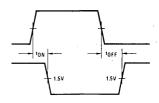
Note 4: Only one output at a time should be shorted.

### **Switching Characteristics**

PARAMETER		CONDITIONS	DS8T26A MAX	DS8T28 MAX	UNITS
Propagat	ion Delay				-
tON	DOUT to ROUT, (Figure 1)	C <sub>L</sub> = 30 pF	14	17	ns
tOFF	DOUT to ROUT, (Figure 1)		14	17	ns
tON	D <sub>IN</sub> to D <sub>OUT</sub> , (Figure 2)	C <sub>L</sub> = 300 pF	14	17	ns
tOFF	D <sub>IN</sub> to D <sub>OUT</sub> , (Figure 2)		14	.17	ns
Data En	able to Data Output				
tPZL	High Z to O, (Figure 3)	C <sub>L</sub> = 300 pF	25	28	ns
<sup>t</sup> PLZ	O to High Z, (Figure 3)		20	23	ns
Receiver	Enable to Receiver Output				
tPZL	High Z to O, (Figure 4)	CL = 30 pF	20	23	ns
tPLZ	O to High Z, (Figure 4)		15 .	18	ns

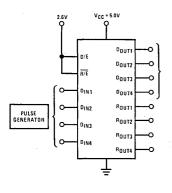
### **AC Test Circuits and Switching Time Waveforms**

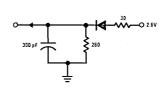


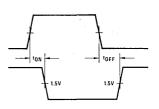


Input pulse: t<sub>r</sub> = t<sub>f</sub> = 5 ns (10% to 90%) Freq = 10 MHz (50% duty cycle) Amplitude = 2.6V

FIGURE 1. Propagation Delay (D<sub>OUT</sub> to R<sub>OUT</sub>)







Input pulse:  $t_r = t_f = 5 \text{ ns } (10\% \text{ to } 90\%)$ Freq = 10 MHz (50% duty cycle) Amplitude = 2.6V

FIGURE 2. Propagation Delay (DIN to DOUT)

### AC Test Circuits and Switching Time Waveforms (Continued)

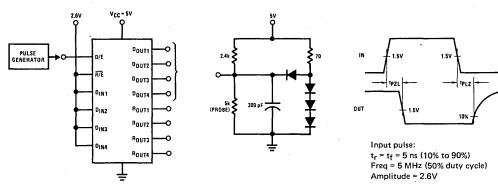


FIGURE 3. Propagation Delay (Data Enable to Data Output)

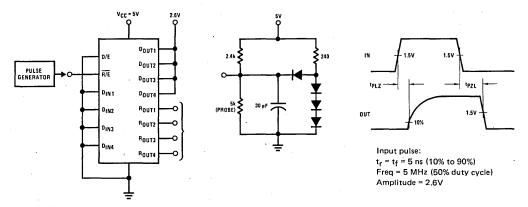


FIGURE 4. Propagation Delay (Receive/Enable to Receiver Output)



# Section 3 Peripheral/Power Drivers



TEMPERATURE RANGE		DESCRIPTION	PAGE
– 55°C to + 125°C	0°C to +70°C	DESCRIPTION	NUMBER
*DP7310	DP8310	Octal Latched Peripheral Drivers	3-4
*DP7311	DP8311	Octal Latched Peripheral Drivers	3-4
*DS1611	DS3611	Dual AND Peripheral Driver	3-11
*DS1612	DS3612	Dual NAND Peripheral Driver	3-11
*DS1613	DS3613	Dual OR Peripheral Driver	3-11
*DS1614	DS3614	Dual NOR Peripheral Driver	3-11
	DS3616	Bubble Memory Coil Driver	3-17
*DS1631	DS3631	Dual AND CMOS Peripheral Driver	3-24
*DS1632	DS3632	Dual NAND CMOS Peripheral Driver	3-24
*DS1633	DS3633	Dual OR CMOS Peripheral Driver	3-24
*DS1634	DS3634	Dual NOR CMOS Peripheral Driver	3-24
_	DS3654	Printer Solenoid Driver	3-29
*****	DS3656	Quad Peripheral Driver	3-33
	DS3658	Quad High Current Peripheral Driver	3-35
	DS3668	Quad High Current Peripheral Driver	3-38
_	DS3669	Quad High Current Peripheral Driver	3-41
-	DS3680	Quad Negative Voltage Relay Driver	3-44
_	DS3686	Dual Positive Voltage Relay Driver	3-47
*DS1687	DS3687	Dual Negative Voltage Relay Driver	3-49
	DS75450	Dual AND Peripheral Driver	3-51
*DS55451	DS75451	Dual AND Peripheral Driver	3-51
*DS55452	DS75452	Dual NAND Peripheral Driver	3-51
*DS55453	DS75453	Dual OR Peripheral Driver	3-51
* DS55454	DS75454	Dual NOR Peripheral Driver	3-51
*DS55461	DS75461	Dual AND Peripheral Driver	3-62
*DS55462	DS75462	Dual NAND Peripheral Driver	3-62
*DS55463	DS75463	Dual OR Peripheral Driver	3-62
*DS55464	DS75464	Dual NOR Peripheral Driver	3-62
_	MM74C908	Dual CMOS 30V Driver	CMOS
<del>-</del>	MM74C918	Dual CMOS 30V Driver	CMOS
•	AN-213	Safe Operating Areas for Peripheral Drivers	3-68

<sup>\*</sup>Also available screened in accordance with MIL-STD-883 Class B. Refer to National Semiconductor's "The Reliability Handbook".



#### PERIPHERAL/POWER DRIVERS

Output High	Latch-Up Voltage (Note 3) (V)	Output Low	Output Low	Propagation Delay	ON Power Supply	Drivers/	Input Compatibility	Logic Function (Driver ON)		e Number erature Range	Page
Voltage (V)	(Note 3) (V)	Voltage (V)	Current (mA)	Typ (ns)	Current (mA)	Package	(Logic)	(Driver UN)	0°C to +70°C	−55°C to +125°C	No.
30		0.5	100	40	152	8	TTL	Note 5	DP8310	DP7310	3-4
30		0.5	100	40	125	. 8	TTL	Note 6	DP8311	DP7311	3-4
20	13.5	0.6	100	70	90	2	TTL .	Note 7	DS3616		3-17
65	30	1.5	600		65	4	TTL/LS	NAND	DS3656		3-33
<sup>`</sup> 70	35	0.7	600	2430	65	4	TTL/LS	NAND	DS3658		3-35
70	Note 8	1.5	600	2000	80	4	TTL/LS	NAND	DS3668		3-38
70	35	0.7	600		65	4	TTL/LS	AND	DS3669		3-41
30	20	0.7	300	31	55	2	TTL	AND	DS75450		3-51
30	20	0.7	300	31	55	2	TTL	AND	DS75451	DS55451	3-51
30	20	0.7	300	31	55	2	TTL	NAND	DS75452	DS55452	3-51
30	20	0.7	300	31	55	2	TTL	OR	DS75453	DS55453	3-51
30	20	0.7	300	31	55	2	TTL	NOR	DS75454	DS55454	3-51
35	30	0.7	300	33	55	2	TTL	AND	DS75461	DS55461	3-62
35	30	0.7	300	33	55	2	TTL	NAND	DS75462	DS55462	3-62
35	30	0.7	300	33	55	. 2	TTL	OR	DS75463	DS55463	3-62
35	30	0.7	300	33	55	2	TTL	NOR	DS75464	DS55464	3-62
56	40	1.4	300	150	8	2	CMOS	AND	DS3631	DS1631	3-24
56	40	1.4	300	150	. 8	2	CMOS	NAND	DS3632	DS1632	3-24
56	40	1.4	300	150	8	2	CMOS	OR	DS3633	DS1633	3-24
- 56	40	1.4	300	. 150	8	. 2	CMOS	NOR	DS3634	DS1634	3-24
80	50	0.7	300	125	75	2	TTL/CMOS	AND	DS3611	DS1611	3-11
80	50	0.7	300	125	75	2	TTL/CMOS	NAND	DS3612	DS1612	3-11
80	50	0.7	300	125	75	.2	. TTL/CMOS	OR	DS3613	DS1613	3-11
80	50	0.7	300	125	75	2	TTL/CMOS	NOR	DS3614	DS1614	3-11
-2.1	-60	-60	-50	10,000	4.4	4	TTL/CMOS	(Note 4)	DS3680		3-44
(Note 1)	56	1.3	300	1000	28	2	TTL/CMOS	NAND	DS3686		3-47
(Note 1)	-56	-1.3	300	1000	28	2	TTL/CMOS	NAND	DS3687	DS1687	3-49
13.5	15	V <sub>CC</sub> -1.8	300	150	0.015	. 2	CMOS	AND	MM74C908, MM74C918		CMO CMO
(Note 1)	45	1.6	250	1000	70	10	(Note 2)	(Note 2)	DS3654		3-29

Note 1: The DS3686, DS3687 and DS3654 contain an internal inductive fly-back clamp circuit connected from the output to ground. As an example, DS3686 driving a relay solenoid connected to 28V would clamp the output voltage fly-back transient at 56V caused by the solenoid's stored inductive current. This clamp protects the circuit output and quenches the fly-back.

Note 2: The DS3654 is a 10-bit shift register followed by 10 enabled drivers. The input circuit is equivalent to a 4k resistor to ground, and the logic input thresholds are 2.8V and 0.8V. The recommended power supply voltage is 7.5V to 9.5V. The circuit can be cascaded to be a 20 or 30-bit shift register.

Note 3: Latch-up voltage is the maximum voltage the output can sustain when switching an inductive load.

Note 4: DS3680 has a differential input circuit.

Note 5: DP8310 inverting, positive edge latching.

Note 6: DP8311 inverting, fall through latch.

Note 7: Bubble memory coil driver.

Note 8: DS3668 35V, latch-up with output fault protection.



## National Semiconductor

## Peripheral/Power Drivers

## DP7310/DP8310/DP7311/DP8311 Octal Latched Peripheral Drivers

## **General Description**

The DP7310/8310, DP7311/8311 Octal Latched Peripheral Drivers provide the function of latching eight bits of data with open collector outputs, each driving up to 100mA DC with an operating voltage range of 30 volts. Both devices are designed for low input currents, high input/output voltages, and feature a power up clear (outputs off) function.

The DP7310/8310 are positive edge latching. Two active low write/enable inputs are available for convenient data bussing without external gating.

The DP7311/8311 are fall through latches. The active low strobe input latches data or allows fall through operation when held at logic "0". The latches are cleared (outputs off) with a logic "0" on the clear pin.

#### Features .

- High current, high voltage open collector outputs
- Low current, high voltage inputs
- All outputs simultaneously sink rated current "DC" with no thermal derating at maximum rated temperature.

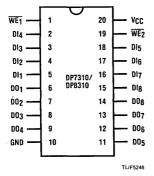
- Parallel latching or buffering
- Separate active low enables for easy data bussing
- Internal "glitch free" power up clear
- 10% V<sub>CC</sub> tolerance

## **Applications**

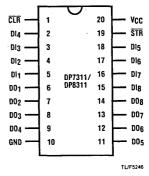
- High current high voltage drivers
- Relay drivers
- Lamp drivers
- LED drivers
- TRIAC drivers
- Solenoid drivers
- Stepper motor drivers
- Level translators
- Fiber-optic LED drivers

## **Connection Diagrams**

#### Dual-In-Line Package \



#### Dual-In-Line Package



Order Number DP7310J, DP7311J, DP8310J, DP8311J, DP8310N or DP8311N See NS Package J20A or N20A

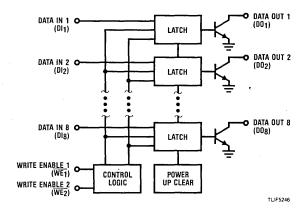
#### **Logic Table**

	DP7310/	DP8310	
Write Enable 1 WE <sub>1</sub>	Data Input DI <sub>1-8</sub>	Data Output DO <sub>1-8</sub>	
0	0	Х	Q
0	-A	0	1
0	<b>√</b>	1	0
<b>√</b>	0	0	1
<b>√</b>	0	1	0
0	1	х	Q
1	o	х	Q
1	1	Х	Q

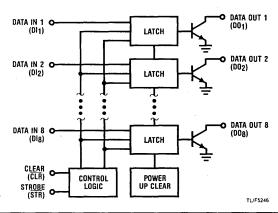
	DP7311/DP8311							
Clear CLR	Strobe STR	Data Input DI <sub>1-8</sub>	Data Output DO <sub>1-8</sub>					
1	1	Х	Q					
1	0	0	1					
1	0	1	0					
0	X	X	1					

X = Don't Care
1 = Outputs Off
0 = Outputs On
Q = Pre-existing Output
← = Positive Edge Transition

## Block Diagram DP7310/DP8310



## Block Diagram DP7311/DP8311



Absolute Maximum Ratings	Operating Conditions					
			Min.	Max.	Units	
Supply Voltage	7.0V	Supply Voltage (V <sub>CC</sub> )	4.5	5.5	٧	
Input Voltage	35V	Temperature			•	
Output Voltage	35V	DP7310/DP7311	<del>-</del> 55	+125	°C	
Maximum Power Dissipation* at 25°C		DP8310/DP8311	. 0	+70	°C	
Cavity Package	1821 mW	Input Voltage		30	٧	
Molded Package	2005 mW	Output Voltage		30	٧	
Storage Temperature Range - 65°	Cto + 150°C					
Lead Temperature (Soldering, 10 seconds)	300°C					

<sup>\*</sup>Derate cavity package 12.1 mW/°C above 25°C; derate molded package 16.0 mW/°C above 25°C.

## DC Electrical Characteristics DP7310/DP8310, DP7311/DP8311 (Notes 2 and 3)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
V <sub>IH</sub>	Logical "1" Input Voltage .		2.0			V
V <sub>IL</sub>	Logical "0" Input Voltage				0.8	٧
V <sub>OL</sub>	Logical "0" Output Voltage DP7310/DP7311	Data outputs latched to logical "0", $V_{CC} = min$ . $I_{OL} = 75 ma$			0.4	V
	DP8310/DP8311	I <sub>OL</sub> = 100 mA		0.35	0.5	v
Іон	Logical "1" Output Current DP7310/DP7311	Data outputs latched to logical "1", V <sub>CC</sub> = min.			500	,
	DP8310/DP8311	V <sub>OH</sub> = 25V V <sub>OH</sub> = 30V		2.5	250	μΑ μΑ
I <sub>IH</sub>	Logical "1" Input Current	$V_{1H} = 2.7V, V_{CC} = max.$		0.1	25	μΑ
l <sub>i</sub>	Input Current at Maximum Input Voltage	V <sub>IN</sub> = 30V, V <sub>CC</sub> = max.		1	250	μΑ
I <sub>IL</sub>	Logical "0" Input Current	$V_{IN} = 0.4V, V_{CC} = max.$		-215	-300	μΑ
V <sub>clamp</sub>	Input Clamp Voltage	I <sub>IN</sub> = -12 mA		-0.8	-1.5	V
I <sub>CC0</sub>	Supply Current, Outputs On  DP7310  DP8310  DP7311  DP8311	Data outputs latched to a logical "0". All inputs are at logical "1", V <sub>CC</sub> = max.		100 100 88 88	125 152 117 125	mA mA mA
l <sub>CC1</sub>	Supply Current, Outputs Off DP7310	Data outputs latched to a logic "1". Other conditions same as I <sub>CC0</sub> .		40	47	mA
	DP8310 DP7311 DP8311			40 25 25	57 34 36	mA mA mA

## AC Electrical Characteristics DP7310/DP8310: V<sub>CC</sub> = 4.5 V, T<sub>A</sub> = -55°C to 125°C

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
t <sub>pd0</sub>	High to Low Propagation Delay Write Enable Input to Output	Figure 1		40	120	ns
t <sub>pd1</sub>	Low to High Propagation Delay Write Enable Input to Output	Figure 1		70	150	ns
tSETUP	Minimum Set-Up Time Data in to Write Enable Input	t <sub>HOLD</sub> = 0 ns Figure 1	45	20		ns
t <sub>pWH</sub> ,	Minimum Write Enable Pulse W'dth	Figure 1	60	25		ns
t <sub>THL</sub>	High to Low Output Transition Time	Figure 1		16	35	ns
t <sub>TLH</sub>	Low to High Output Transition Time	Figure 1		38	70	ns
C <sub>IN</sub>	"N" Package Note 4			5	15	pF

## AC Electrical Characteristics DP7311/DP8311: V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C

Symbol	Parameter	Parameter Conditions		Тур.	Max.	Units
t <sub>pd0</sub>	High to Low Propagation Delay Data In to Output	Figure 2		30	60	ns
t <sub>pd1</sub>	Low to High Propagation Delay Data In to Output	Figure 2		70	100	ns
t <sub>SETUP</sub>	Minimum Set-Up Time Data In to Strobe Input	t <sub>HOLD</sub> = 0 ns Figure 2	0	-25		ns
t <sub>pWL</sub>	Minimum Strobe Enable Pulse Width	Figure 2	60	35		ns
t <sub>pdC</sub>	Propagation Delay Clear to Data Output	Figure 2		70	135	ns
tpWC	Minimum Clear Input Pulse Width	Figure 2	60	25		ns
t <sub>THL</sub>	High to Low Output Transition Time	Figure 2		20	35	ns
t <sub>TLH</sub>	Low to High Output Transition Time	Figure 2		38	60	ns
C <sub>IN</sub>	Input Capacitance — Any Input	Note 4		5	15	pF

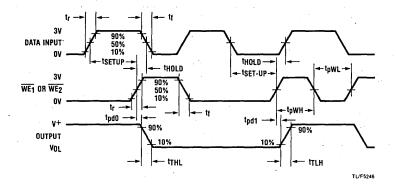
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min./max. limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DP7310/DP7311 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C for the DP8310/DP8311. All typical values are for  $T_A = 25^{\circ}$ C,  $V_{CC} = 5V$ .

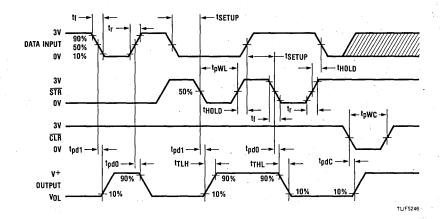
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted.

Note 4: Input capacitance is guaranteed by periodic testing.  $f_{TEST} = 10 \, kHz$  at 300 mV,  $T_A = 25 \, ^{\circ}C$ 

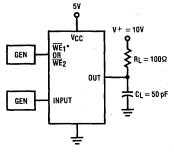
## Switching Time Waveform DP7310/DP8310



## Switching Time Waveform DP7311/DP8311

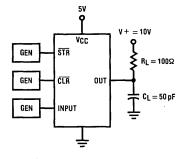


## Switching Time Test Circuits DP7310/DP8310 DP7311/DP8311



\* $\overline{WE}_1 = 0V$  WHEN THE INPUT =  $\overline{WE}_2$ 

TUF5246



PULSE GENERATOR CHARACTERISTICS:  $Z_0 = 50\Omega, \ t_f = t_f = 5 \ \text{ns}$ 

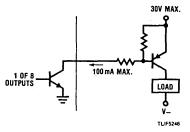
TL/F5246

FIGURE 1

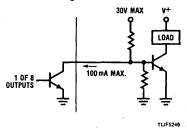
FIGURE 2

## Typical Applications DP8310/11 Buffering High Current Device (Notes 1 and 2)

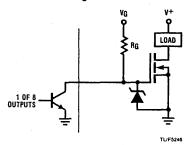
#### **PNP High Current Driver**



#### **NPN High Current Driver**

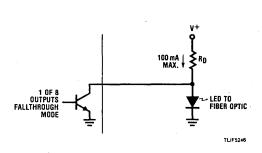


#### **VMOS High Current Driver**

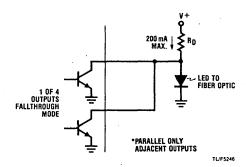


#### Eight Output/Four Output Fiber Optic LED Driver

#### DP8311 100 mA Drivers

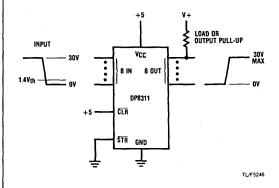


#### DP8311 Parallel Outputs (200 mA) Drivers\*

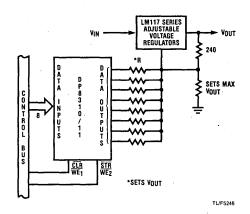


## Typical Applications (cont'd)

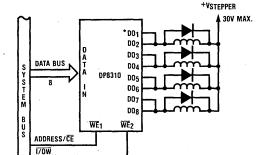
8-Bit Level Translator-Driver



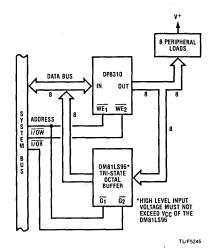
Digital Controlled 256 Level
Power Supply from 1.2 Volts to 30 Volts



200 mA Drive for a 4 Phase Bifilar Stepper Motor



#### Reading the State of the Latched Peripherals



Note 1: Always use good V<sub>CC</sub> bypass and ground techniques to suppress transients caused by peripheral loads.

\*PARALLEL ONLY

ADJACENT OUTPUTS

Note 2: Printed circuit board mounting is required if these devices are operated at maximum rated temperature and current (all outputs on DC).

TL/F5246

## National Semiconductor

## Peripheral/Power Drivers

## DS1611/DS3611, DS1612/DS3612, DS1613/DS3613, DS1614/DS3614 Dual Peripheral Drivers

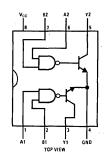
## **General Description**

The DS1611 series of dual peripheral drivers was designed for those applications where a higher breakdown voltage is required than that provided by the DS75451 series. The pin outs for the circuits are identical to those of the DS75451 through DS75454. The DS1611 series parts feature high voltage outputs (80V breakdown in the "OFF" state) as well as high current (300 mA in the "ON" state). Typical applications include power drivers, relay drivers, lamp drivers, MOS drivers, and memory drivers.

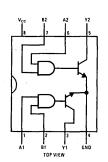
#### **Features**

- 300 mA output current capability per driver
- High voltage outputs (80V)
- TTL compatible
- Input clamping diodes
- Choice of logic function

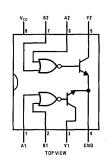
## Connection Diagrams (Dual-In-Line and Metal Can Packages)



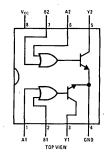
Order Number DS1611J-8, DS3611J-8 or DS3611N



Order Number DS1612J-8, DS3612J-8 or DS3612N

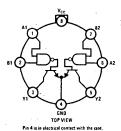


Order Number DS1613J-8, DS3613J-8 or DS3613N

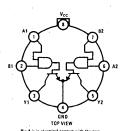


Order Number DS1614J-8, DS3614J-8 or DS3614N

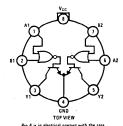
#### See NS Package J08A or N08A



**Order Number** DS1611H or DS3611H

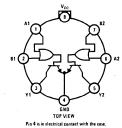


Order Number DS1612H or DS3612H



Order Number

DS1613H or DS3613H See NS Package H08C



**Order Number** DS1614H or DS3614H

Absolute Maximum Ratir	1 <b>GS</b> (Note 1)	Operating Condi			
Supply Voltage, V <sub>CC</sub>	7.0V	Supply Voltage (VCC)	MIN	MAX	UNITS
Input Voltage	5.5V	DS161X	4.5	5.5	V
Output Voltage (Note 5)	80V	DS361X	4.75	5.25	V
Continuous Output Current Storage Temperature Range	300 mA 65°C to +150°C	Temperature (T <sub>A</sub> ) DS161X	-55	+125	°c
Maximum Power Dissipation* at 25°C Cavity Package	1133 mW	DS361X	0	+70	°C
Molded Package TO-5 Package Lead Temperature (Soldering, 10 seconds)	1022 mW 787 mW 300°C	*Derate cavity package 7.6 m package 8.2 mW/ °C above 25 °C above 25°C.	W/°C above 29 °C; derate TO-	5°C; derate 5 package 5	molded .25 mW/

## Electrical Characteristics DS1611/DS3611, DS1612/DS3612, DS1613/DS3613, DS1614/DS3614 (Notes 2 and 3)

	PARAMETER	CONDITIONS			MIN	TYP	MAX	UNI
V <sub>IH</sub>	High Level Input Voltage	(Figure 1)			2			V
V <sub>IL</sub>	Low Level Input Voltage	(Figure 2)					0.8	\
/,	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>I</sub> = -12 m	A, (Figure 3)			-1.2	-1.5	,
/ <sub>OL</sub>	Low Level Output Voltage		T	I <sub>OL</sub> = 100 mA		0.2	0.5	,
			DS1611, V <sub>IL</sub> = 0.8V	I <sub>OL</sub> = 300 mA		0.45	0.8	,
				I <sub>OL</sub> = 100 mA		0.2	0.5	,
			DS1612, V <sub>IH</sub> =2V	I <sub>OL</sub> = 300 mA		0.45	0.8	,
			DS1613, V <sub>IL</sub> =0.8V	I <sub>OL</sub> = 100 mA		0.2	0.5	
			DS1613, VIL-0.6V	I <sub>OL</sub> = 300 mA		0.45	0.8	
	e.*	•	DS1614, V <sub>IH</sub> =2V	I <sub>OL</sub> = 100 mA		0.2	0.5	<u> </u>
		V <sub>CC</sub> = Min,(Figure 1)	D01011, 11H 21	I <sub>OL</sub> = 300 mA	<u> </u>	0.45	0.8	<u> </u>
			DS3611, V <sub>IL</sub> =0.8V	I <sub>OL</sub> = 100 mA	ļ	0.2	0.4	<u> </u>
				I <sub>OL</sub> = 300 mA	<del> </del>	0.45	0.7	
			DS3612, V <sub>IH</sub> =2V	I <sub>OL</sub> = 100 mA	ļ	0.2	0.4	
	· •			I <sub>OL</sub> = 300 mA	<del> </del>	0.45	0.7	-
	•		DS3613, V <sub>IL</sub> =0.8V	I <sub>OL</sub> = 100 mA		0.2	0.4	
				I <sub>OL</sub> = 300 mA	<del> </del>	0.45	0.7	-
			DS3614, V <sub>IH</sub> =2V	I <sub>OL</sub> = 100 mA	<del> </del>	0.2 0.45	0.4	-
				I <sub>OL</sub> = 300 mA	<del> </del>	0.45	0.7	
/он .	Output Breakdown Voltage		V <sub>IH</sub> = 2V, I <sub>OH</sub> = 300 μA	DS1611, DS1613	80			
			V <sub>IH</sub> = 2V,	DS3611,	<del>                                     </del>	<u> </u>	<del> </del>	<del>                                     </del>
		V <sub>CC</sub> = Min,(Figure 1)	I <sub>OH</sub> = 100 μA	DS3613	80			i '
			V <sub>IL</sub> = 0.8V,	DS1612,	<del> </del>	<del> </del>	ļ	<del>                                     </del>
	* "		1 <sub>OH</sub> = 300 μA	DS1614	80			'
	•		$V_{1L} = 0.8V$ ,	DS3612,				١ ,
			I <sub>OH</sub> = 100 μA	DS3614	80	1		1
1	Input Current at Maximum Input Voltage	V <sub>CC</sub> = Max, V <sub>I</sub> = 5.5V	, (Figure 2)				1	m
IH.	High Level Input Current	V <sub>CC</sub> = Max, V <sub>1</sub> = 2.4V	(Figure 2)				40	μ
IL	Low Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 0.4V	I, (Figure 3)			-1	-1.6	m
ссн	Supply Current		T .	DS1611/			1	
				DS3611	1	1	11	m
			V <sub>1</sub> = 5V	DS1613/			14	
		V <sub>CC</sub> = Max, Outputs		DS3613	<u> </u>		14	m
		High, (Figures 4 and 5)		DS1612/		1	14	m
		٠	V <sub>1</sub> = 0V	DS3612		<u> </u>		<u>'</u> "
			1 - 0 4	DS1614/			17	m
			<u> </u>	DS3614	ļ	<b></b>	<u> </u>	ļ
lccL	Supply Current			DS1611/			69	m
			V <sub>1</sub> = 0V	DS3611	<del> </del>	<u> </u>	99	<del>  "</del>
			101-00	DS1613/	1		73	l m
		V <sub>CC</sub> = Max, Outputs		DS3613	<del> </del>	<del> </del>	<del></del>	<del> </del>
		Low, (Figures 4 and 5)	']	DS1612/	1		71	m
			V <sub>1</sub> = 5V	DS3612 DS1614/	<del> </del>	<del> </del>	<del> </del>	<del> </del>
			] .	DS1614/	1	1	79	m
			1	D33014	[	I	, ,	1 "

## Switching Characteristics V<sub>CC</sub> = 5.0V, T<sub>A</sub> = 25°C

DS1611/DS3611, DS1612/DS3612, DS1613/DS3613, DS1614/DS3614

	PARAMETER	CONDITIONS	CONDITIONS		IN TYP	MAX	UNITS
t <sub>PD1</sub>	Propagation Delay Time, Low-To-High Level Output		DS1611/ DS3611		130		ns
		$I_{O} \approx 200 \text{ mA, } C_{L} = 15 \text{ pF, } R_{L} = 50\Omega,$	DS1612/ DS3612		110		ns
		(Figure 6)	DS1613/ DS3613		125		ns
			DS1614/ DS3614		220		ns
t <sub>PD0</sub>	Propagation Delay Time, High-To-Low Level Output		DS1611/ DS3611		125		ns
		$I_O \approx 200 \text{ mA}, C_L = 15 \text{ pF}, R_L = 50\Omega$ ,	DS1612/ DS3612		110		ns
	(Figure 6)	DS1613/ DS3613		125		ns	
	.		DS1614/ DS3614		150		ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C temperature range for the DS3611, DS3612, DS3613, DS3614, and  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS1611, DS1612, DS1613 and DS1614. All typical values are for  $T_{A} = 25^{\circ}$ C and  $V_{CC} = 5V$ .

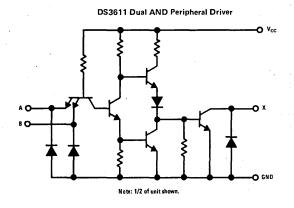
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

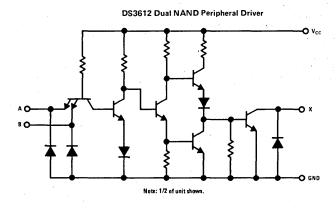
Note 4: Maximum junction temperature is 150°C.

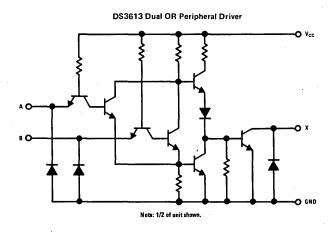
Note 5: Maximum voltage to be applied to either output in the "OFF" state.

Note 6: Delay is measured with a 50 $\Omega$  load to 10V, 15 pF load capacitance, measured from 1.5V input to 50% point on output.

## Schematic Diagrams (each driver)

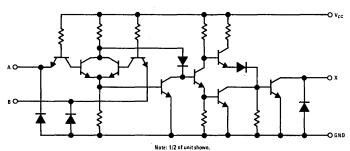




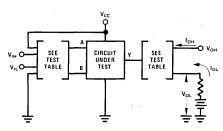


## Schematic Diagrams (Continued)

#### DS3614 Dual NOR Peripheral Driver



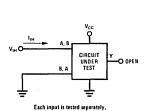
## **Test Circuits**

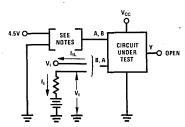


	INPUT	OTHER	OUTPUT		
CIRCUIT	UNDER TEST	INPUT	APPLY	MEASURE	
DS3611	V <sub>IH</sub> V <sub>IL</sub>	V <sub>IH</sub> V <sub>CC</sub>	I <sub>OH</sub>	V <sub>OH</sub> V <sub>OL</sub>	
DS3612	V <sub>IH</sub> V <sub>IL</sub>	V <sub>IH</sub> V <sub>CC</sub>	lot lon	V <sub>OL</sub> V <sub>OH</sub>	
DS3613	V <sub>IH</sub> V <sub>IL</sub>	GND V <sub>IL</sub>	lon loc	V <sub>OH</sub>	
DS3614	V <sub>IH</sub> V <sub>IL</sub>	GND V <sub>IL</sub>	I <sub>OL</sub> I <sub>OH</sub>	V <sub>OL</sub> V <sub>OH</sub>	

NOTE: Each input is tested separately.

FIGURE 1.  $V_{IH}$ ,  $V_{IL}$ ,  $V_{OH}$ ,  $V_{OL}$ 

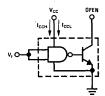




Note 1: Each input is tested separately.

Note 2: When testing DS3613 and DS3614 input not under test is grounded. For all other circuits it is at 4.5V.

FIGURE 2. I<sub>I</sub>, I<sub>IH</sub> FIGURE 3. V<sub>I</sub>, I<sub>IL</sub>



Both gates are tested simultaneously.

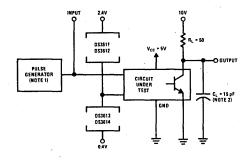


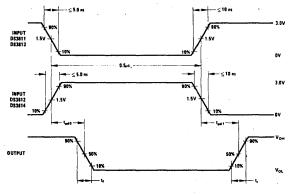
Both gates are tested simultaneously.

FIGURE 4. ICCH, ICCL for AND, NAND Circuits

FIGURE 5. ICCH, ICCL for OR, NOR Circuits

## Test Circuit and Switching Time Waveforms





Note 1: The pulse generator has the following characteristics: FRR = 1.0 MHz,  $Z_{OUY} \approx 50\Omega$ . Meto 2: C. includes graph and iis conscious:

FIGURE 6. Switching Times of Complete Drivers



## **DS3616 Bubble Memory Coil Driver**

## **General Description**

The DS3616 bubble memory coil driver provides the function of driving the high current coils of a bubble memory device. The control inputs A, B,  $\overline{CS}$  and HLD-EN are TTL compatible to insure easy interfacing to MOS control circuits. Internal logic controls the output sinking and sourcing transistors to drive the X and Y bubble memory coils in a bridged push-pull configuration.

Sourcing transistors are driven into saturation by the onchip voltage booster for maximum current drive to the coil.

The internal power up/down control circuit prevents glitches and noise on the outputs during system initialization.

CS enables the output drive transistors. A pause capability is available from the HLD-EN input to allow asynchronous operation (refer to Typical Applications data).

The DS3616 is characterized to operate from 0°C to 70°C.

#### **Features**

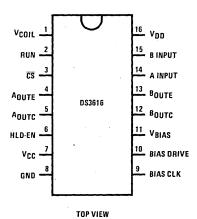
■ Two high current push-pull outputs

**Peripheral/Power Drivers** 

- TTL compatible low current inputs
- Two power supplies + 5V and + 12V
- Internal clamp diodes
- Power up/down control circuit
- Optional internal voltage booster
- Run output for function driver control

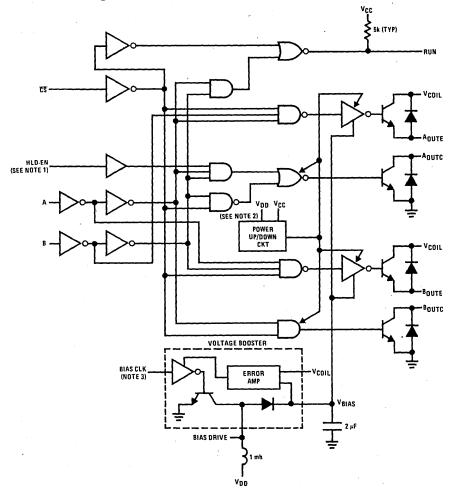
## **Connection Diagram**

#### **Dual-In-Line Package**



Order Number DS3616N See NS Package N16A

## **Functional Block Diagram**



## Functional Tables (Note 2)

HLD.	HLD-EN = 0									
Α	В	ĈŜ	A <sub>OUT</sub>	B <sub>OUT</sub>	Run					
Χ.	Х	1	Z	Z	. 0					
0	0	0	Z	Z	1 -					
0	1	0	0	1	1					
1	0	0	1	0	1					
1	1	0	0	0	0					

HLD-EN = 1								
Α	В	<del>cs</del>	A <sub>OUT</sub>	Bout	Run			
Х	Х	1	Z	Z	0			
0	0	0	Z	Z	1			
0	1	0	0	. 1	1			
1	0	. 0	1	0	1			
1	1 .	0	Z	0	0			

Note 1: When used as Y driver, HLD-EN is in Logic "0" state.

Note 2: Run output is independent of the power-up clear circuit and functions down to  $V_{CC} = 3V$ . (See Typical Applications.)

Note 3: If BIAS CLK stops, it must remain in a Logic "1" state to prevent excessive DC current in the inductor.

#### **Absolute Maximum Ratings (Note 1) Recommended Operating Conditions** Typ Max Units Min Supply Voltage (V<sub>CC</sub>) 7V T<sub>A</sub> Operating Temperature Supply Voltage (VDD) 15V 0 70 °C Coil Source Voltage (V<sub>COIL</sub>) 14V Supply Voltage (V<sub>CC</sub>) 4.75 (4.5)\*\* 5 5.25 ٧ Supply Voltage (VDD) 11.4 (10.8)\*\* 12.6 ٧ V<sub>BIAS</sub>-V<sub>COIL</sub> 6.5V Coil Source Voltage (VCOIL) Peak Output Current (Coil Outputs) 7 10 13.5 1A VBIAS-VCOIL 4.0 4.8 6 V<sub>BIAS</sub> Drive Current 300 mA Peak Coil Output Current 950 mΑ Maximum Power Dissipation\* at 25°C Molded Package 1950 mW Peak V<sub>BIAS</sub> Drive Current mΑ \*Derate molded package 15.6 mW/°C above 25°C. \*\* Min supply voltage for functionality during power up/down sequences.

#### Electrical Characteristics (Notes 2 and 3)

	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	High Level Input Voltage	V <sub>CC</sub> = 4.75V	2.0			V
V <sub>IL</sub>	Low Level Input Voltage	V <sub>CC</sub> = 4.75V			0.8	V
V <sub>OD</sub>	Differential Output Voltage	$I_O = 850$ mA, $V_{COIL} = 13.5$ V, $V_{BIAS} = 18.5$ V, $V_{CC} = 4.75$ V, $V_{DD} = 11.4$ V	11.7	12.2	12.7	٧
VOCLAMP	Output Clamp Diode Voltage	I <sub>O</sub> = -850 mA, Lower Clamp	- 0.9		- 1.5	V
		I <sub>O</sub> = 850 mA, Upper Clamp	0.9		1.5	٧
VICLAMP	Input Clamp Diode Voltage	I <sub>I</sub> = -12 mA		- 0.9	- 1.5	٧
$V_{OHR}$	Run High Level Output Voltage	$I_{OH} = -400 \mu\text{A},  V_{CC} = 4.75 \text{V}$	2.4	3.3		V
		$I_{OH} = -100 \mu\text{A},  V_{CC} = 4.75 \text{V}$	3.5	4.1	4.45	V
V <sub>OLR</sub>	Run Low Level Output Voltage	$I_{OL} = 5 \text{ mA}, V_{CC} = 4.75V$		0.2	0.5	٧
l <sub>l</sub>	Maximum Input Current at Maximum Input Voltage	$V_{CC} = 5.25V, V_{IN} = 5.5V$		1	100	μА
I <sub>IH</sub>	High Level Input Current	$V_{CC} = 5.25V, V_{IN} = 2.4V$		1	40	μА
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = 5.25V, V <sub>IL</sub> = 0.4V		- 160	- 250	μА
V <sub>CCEN</sub>	V <sub>CC</sub> Power Up Enable Voltage		3.2	3.8	4.4	V
V <sub>DDEN</sub>	V <sub>DD</sub> Power Up Enable Voltage		8.0	9.5	10.5	٧
V <sub>BIAS</sub>	Regulator Threshold Voltage	$V_{COIL} = 10V, V_{DD} = 12V, V_{CC} = 5V$	14.0	14.8	16	V
V <sub>F</sub>	· Bias Diode Voltage	I <sub>F</sub> = 100 mA		0.9	1.5	V
I <sub>R</sub>	Bias Diode Leakage Current	V <sub>REVERSE</sub> = 20V		5	500	μА
V <sub>OL</sub>	V <sub>CE(SAT)</sub> of V <sub>BIAS</sub> Output Transistor	V <sub>CC</sub> = 4.75V, Bias Drive = 100 mA		0.3	0.6	٧
I <sub>OFF</sub>	Leakage Current of V <sub>BIAS</sub> Output Transistor	V <sub>OH</sub> = 20V		5	500	μА
I <sub>LCU</sub>	Leakage Current of the Upper Drive	$V_{COIL} = 13.5V$ , $V_{OUT} = 0V$		10	1000	μА
I <sub>LCL</sub>	Leakage Current of the Lower Drive	V <sub>OUT</sub> = 15V		10	1000	μΑ
I <sub>CC1(E)</sub>	V <sub>CC</sub> Supply Current Chip Enabled	A = 3.0V, B = 0.4V, $\overline{CS}$ = 0.4V, HLD-EN = 0.4V, $V_{CC}$ = 5.25V		55	90	mA
I <sub>CC0(D)</sub>	V <sub>CC</sub> Supply Current Chip Disabled	$A = B = HLD-EN = 0.4V, \overline{CS} = 3.0V,$ $V_{CC} = 5.25V$		17	33	mA
I <sub>DD</sub>	V <sub>DD</sub> Supply Current	V <sub>DD</sub> = 12.6V		4.5	7	mA
I <sub>BIAS1(E)</sub>	V <sub>BIAS</sub> Current Chip Enabled	V <sub>BIAS</sub> = 18.5V, V <sub>COIL</sub> = 13.5V Same Input Conditions as I <sub>CC1</sub>		40	60	mA
I <sub>BIASO(D)</sub>	V <sub>BIAS</sub> Current Chip Disabled	V <sub>BIAS</sub> = 18.5V, V <sub>COIL</sub> = 13.5V Same Input Conditions as I <sub>CC0</sub>		5	8	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

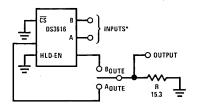
Note 2: Unless otherwise specified min/max limits apply across the 0°C to 70°C temperature range for the DS3616.  $V_{CC} = 5V \pm 5\%$ ,  $V_{DD} = 12V \pm 5\%$ . During power up/down, for functional operation,  $V_{CC} = +5\%$ , -10%;  $V_{DD} = +5\%$ , -10%.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

## Switching Characteristics $T_A = 0$ °C to 70°C, $V_{CC} = 4.75$ V, $V_{DD} = 11.4$ V

	Parameter	Conditions	Min	Тур	Max	Units
t <sub>R(E)</sub>	Rise Time for A <sub>OUT</sub> or B <sub>OUT</sub> Emitters	Figure 1		40	100	ns
t <sub>F(E)</sub>	Fall Time for A <sub>OUT</sub> or B <sub>OUT</sub> Emitters	rigule i		15	50	ns
t <sub>R(C)</sub>	Rise Time for A <sub>OUT</sub> or B <sub>OUT</sub> Collectors	5:0		15	50	ns
t <sub>F(C)</sub>	Fall Time for A <sub>OUT</sub> or B <sub>OUT</sub> Collectors	Figure 2		25	50	ns
t <sub>ON(E)</sub>	Turn ON Time for A <sub>OUT</sub> or B <sub>OUT</sub> Emitters	Figure 1		85	150	ns
t <sub>OFF(E)</sub>	Turn OFF Time for A <sub>OUT</sub> or B <sub>OUT</sub> Emitters	Figure		45	120	ns
t <sub>ON(C)</sub>	Turn ON Time for A <sub>OUT</sub> or B <sub>OUT</sub> Collectors	Figure 2		70	150	ns
t <sub>OFF(C)</sub>	Turn OFF Time for A <sub>OUT</sub> or B <sub>OUT</sub> Collectors	Figure 2		55	120	ns
t <sub>CSON(E)</sub>	Time for CS to Enable Output Emitters	Figure 2		70	150	ns
t <sub>CSOFF(E)</sub>	Time for CS to TRI-STATE® Output Emitters	Figure 3		50	120	' ns
t <sub>CSON(C)</sub>	Time for CS to Enable Output Collectors	Figure 4		50	120	ns
t <sub>CSOFF(C)</sub>	Time for CS to TRI-STATE Output Collectors	Figure 4		60	120	ns
t <sub>R(RUN)</sub>	Rise Time for Run Output			50	70	ns
t <sub>F(RUN)</sub>	Fall Time for Run Output	Figure 5		10	20	ns
t <sub>ON(RUN)</sub>	Turn ON Time for Run Output	Figure 5		70	110	. ns
t <sub>OFF(RUN)</sub>	Turn OFF Time for Run Output			40	70	ns
t <sub>PLZ</sub>	Propagation Delay for HLD-EN to TRI-STATE A <sub>OUT</sub> Collector	Eiguro 6		65	120	ns
t <sub>PZL</sub>	Propagation Delay for HLD-EN Turn ON A <sub>OUT</sub> Collector	Figure 6		45	120	ns
tCHARGE	Charge Up Time for V <sub>BIAS</sub>	1 mh, 2 $\mu$ F, f <sub>CLK</sub> = 800 kHz		2	5	ms
t <sub>dON</sub>	Turn ON Time of Clamp Diodes	Figure 7		30	50	ns
IMB	DC Imbalance under AC Conditions	Figure 8		± 0.1		V
BIASCLK	Duty Cycle		40	50	60	%
DIMO OFF	Frequency	1.	600	800	1000	kH.

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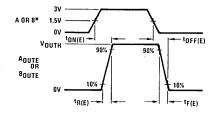
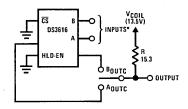


FIGURE 1. Test Set-Up and Timing Waveforms for A<sub>OUT</sub> and B<sub>OUT</sub> Emitters



\* Ground A input if B is the driven input or Ground B if A is the driven input.

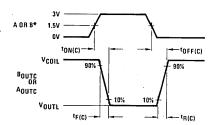
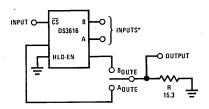


FIGURE 2. Test Set-Up and Timing Waveforms for  $A_{OUT}$  and  $B_{OUT}$  Collectors



\* For A<sub>OUTE</sub> and B<sub>OUTC</sub>, A = 3V, B = 0V; for B<sub>OUTE</sub> and A<sub>OUTC</sub>, A = 0V, B = 3V.

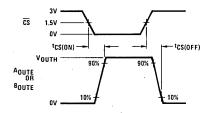
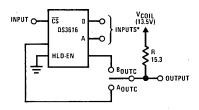


FIGURE 3. Test Set-Up and Timing Waveforms for A<sub>OUT</sub> and B<sub>OUT</sub> Emitters



\* For A<sub>OUTE</sub> and B<sub>OUTC</sub>, A = 3V, B = 0V; for B<sub>OUTE</sub> and A<sub>OUTC</sub>, A = 0V, B = 3V.

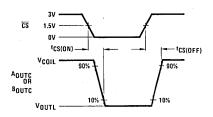
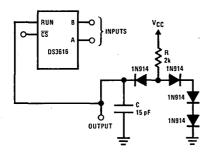


FIGURE 4. Test Set-Up and Timing Waveforms for A<sub>OUT</sub> and B<sub>OUT</sub> Collectors



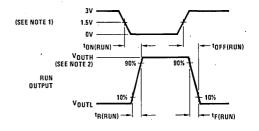
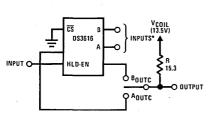
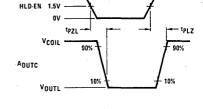


FIGURE 5. Test Set-Up and Timing Waveforms for Run Output





\*Input Conditions: A = B = 3V

FIGURE 6. Test Set-Up and Timing Waveforms for  $A_{\mbox{\scriptsize OUTC}}$  TRI-STATE

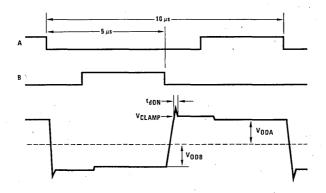


FIGURE 7. AC Switching Characteristics

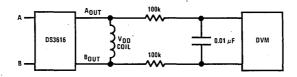
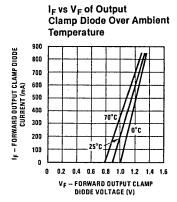


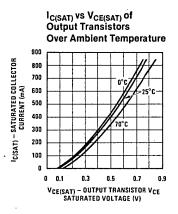
FIGURE 8. DC Imbalance Test Circuit

Note 1: Output waveforms may be generated with  $\overline{CS}$  = input, A = B = 0V or B = input, A = 3V,  $\overline{CS}$  = 0V

Note 2: Reference  $V_{OUTH}$  is set at 4V, which includes the active pull-up voltage plus charge-up voltage due to the internal 5 k $\Omega$  resistor to  $V_{CC}$  (typical rise time = 12 ns).

## **Typical Characteristics**





## Typical Applications (Figures 9 and 10)

The coil driver circuit is used to generate triangular current waveforms for the bubble memory coils. The currents are generated by switching the coil driver in such a way that a voltage pulse is applied to the coil. The coil inductance integrates the voltage into a current ramp. When the pulse is switched OFF the current is commutated by two on-chip clamp diodes and current ramps down to zero. At that time the opposite polarity pulse is applied to the coil, which causes the current to ramp in the opposite direction.

The Run output drives the chip enable input of the function driver (DS3615). It goes low when A=B=1, indicating the controller has stopped the coils, or when  $\overline{CS}=1$  indicating the bubble is not selected. In the event of a system power loss, A and B are to be set to logic 1 by the controller. This stops the coil driver and causes the Run output to go to zero which disables the function driver. The Run output is guaranteed to stay at Logic "0" and coil drive outputs in Logic "0" state or high impedance condition (if A=B=1 or  $\overline{CS}=1$ ) down to  $V_{CC}=3V_{\rm s}$ , at which time the function driver and coil driver power supply sensors will have disabled all outputs driving the bubble.

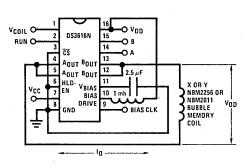


FIGURE 9. Typical Application

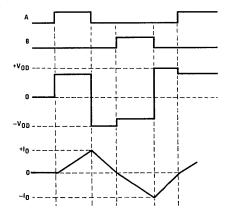


FIGURE 10. Coil Current and Voltage Waveforms

# National Semiconductor

## **Peripheral/Power Drivers**

## DS1631/DS3631, DS1632/DS3632, DS1633/DS3633, DS1634/DS3634 CMOS Dual Peripheral Drivers

### **General Description**

The DS1631 series of dual peripheral drivers was designed to be a universal set of interface components for CMOS circuits.

Each circuit has CMOS compatible inputs with thresholds that track as a function of  $V_{CC}$  (approximately  $1/2\ V_{CC}$ ). The inputs are PNPs providing the high impedance necessary for interfacing with CMOS.

Outputs have high voltage capability, minimum breakdown voltage is 56V at  $250\mu A$ .

The outputs are Darlington connected transistors. This allows high current operation (300 mA max) at low internal  $V_{\rm CC}$  current levels since base drive for the output transistor is obtained from the load in proportion to the required loading conditions. This is essential in order to minimize loading on the CMOS logic supply.

Typical  $V_{CC}$  = 5V power is 28 mW with both outputs ON.  $V_{CC}$  operating range is 4.5V to 15V.

The circuit also features output transistor protection if the  $V_{CC}$  supply is lost by forcing the output into the

high impedance OFF state with the same breakdown levels as when  $V_{CC}$  was applied.

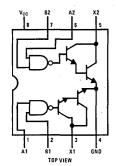
Pin-outs are the same as the respective logic functions found in the following popular series of circuits: DS75451, DS75461, DS3611. This feature allows direct conversion of present systems to the MM74C CMOS family and DS1631 series circuits with great power savings.

The DS1631 series is also TTL compatible at  $V_{CC} = 5V$ .

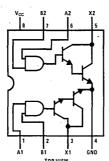
#### **Features**

- CMOS compatible inputs
- TTL compatible inputs
- High impedance inputs
- PNP's
- High output voltage breakdown
- 56V min
- High output current capability
- 300 mA max
- Same pin-outs and logic functions as DS75451, DS75461 and DS3611 series circuits
- Low V<sub>CC</sub> power dissipation (28 mW both outputs "ON" at 5V)

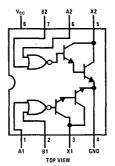
## Connection Diagrams (Dual-In-Line and Metal Can Packages)



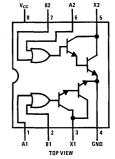
Order Number DS1631J-8, DS3631J-8 or DS3631N



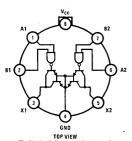
Order Number DS1632J-8, DS3632J-8 or DS3632N



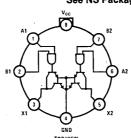
er DS1632J-8, Order Number DS1633J-8, or DS3632N DS3633J-8 or DS3633N See NS Package J08A or N08A



Order Number DS1634J-8, DS3634J-8 or DS3634N



Order Number
DS1631H or DS3631H

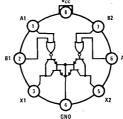


TOP VIEW
(Pin 4 is electrically connected to the case.)

Order Number

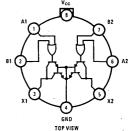
Order Number

Order DS1632H or DS3632H
See NS Package H08C



TOP VIEW
(Pin 4 is electrically connected to the case.

Order Number
DS1633H or DS3633H



Order Number
DS1634H or DS3634H

Absolute Maximum Ratings (Note 1)		Operating Conditions			
Supply Voltage	16V		MIN	MAX	UNITS
Voltage at Inputs	-0.3V to V <sub>CC</sub> +0.3V	Supply Voltage, V <sub>CC</sub>			
Output Voltage	56V	DS1631/DS1632/	4.5	15	V
Storage Temperature Range	-65°C to +150°C	DS1633/DS1634	4.5		•
Maximum Power Dissipation* at 25°C					
Cavity Package	1133 mW	DS3631/DS3632/	4.75	15	V
Molded Package	1022 mW	DS3633/DS3634			
TO-5 Package	787 mW	Temperature, T <sub>△</sub>			
Lead Temperature (Soldering, 10 second		DS1631/DS1632/	55	+125	°c
*Derate cavity package 7.6 mW/°C abov	ve 25°C; derate molded	DS1633/DS1634			
*Derate cavity package 7.6 mW/°C above package 8.2 mW/°C above 25°C; derate °C above 25°C.	TO-5 package 5.2 mW/	DS3631/DS3632/	0	+70	°C
Electrical Characteristi	CS (Notes 2 and 3)	DS3633/DS3634			

	PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS
ALL C	IRCUITS							
VIH	Logical "1" Input Voltage		V <sub>CC</sub> = 5V		3.5	2.5		٧
		(Figure 1)	V <sub>CC</sub> = 10V		8.0	5		٧
			V <sub>CC</sub> = 15V		12.5	7.5		V
VIL	VIL Logical "0" Input Voltage		V <sub>CC</sub> = 5V			2.5	1.5	٧
		(Figure 1)	V <sub>CC</sub> = 10V			5.5	2.0	V
			V <sub>CC</sub> = 15V	•		7.5	2.5	V
ηн	Logical "1" Input Current	V <sub>CC</sub> = 15V, V <sub>IN</sub> = 15V	, (Figure 2)			0.1	10	μΑ
HL	Logical "0" Input Current	V <sub>IN</sub> = 0.4V, (Figure 3)	V <sub>CC</sub> = 5V			-50	-120	μΑ
			V <sub>CC</sub> = 15V			-200	-360	μΑ
Voн	Output Breakdown Voltage	V <sub>CC</sub> = 15V, I <sub>OH</sub> = 250	μΑ, (Figure 1)		56	65		V
VOL	Output Low Voltage	V <sub>CC</sub> = Min, (Figure 1),	I <sub>OL</sub> = 100 mA			0.85	1.1	. v
		DS1631, DS1632,	IOL = 300 mA			1.1	1.4	v
		DS1633, DS1634						
		V <sub>CC</sub> = Min, (Figure 1),	IOL = 100 mA			0.85	1.0	٧
		DS3631, DS3632, DS3633, DS3634	IOL = 300 mA			1.1	1.3	V
DS1631	1/DS3631	200000, 200004						<del></del>
	Supply Currents		V <sub>CC</sub> = 5V	Output Low		7	11	mA
(CC(0)	Supply Currents	V <sub>IN</sub> = 0V, (Figure 4)	V <sub>CC</sub> = 15V	Both Drivers		14	20	mA
<sup>1</sup> CC(1)			V <sub>CC</sub> = 5V, V <sub>IN</sub> = 5V	Output High		2	3	mA
.00(1)		(Figure 4)	V <sub>CC</sub> = 15V, V <sub>IN</sub> = 15V	1 ' ' 1		7.5	10	mA
<sup>t</sup> PD1	Propagation to "1"	V <sub>CC</sub> = 5V, T <sub>A</sub> = 25°C, (Figure 5)	V <sub>CC</sub> = 5V, T <sub>A</sub> = 25°C, C <sub>L</sub> = 15 pF, R <sub>L</sub> = 50Ω, V <sub>L</sub> = 10V,			200		ns
tPD0	Propagation to "O"	V <sub>CC</sub> = 5V, T <sub>A</sub> = 25°C, (Figure 5)	C <sub>L</sub> = 15 pF, R <sub>L</sub> = 50Ω, V <sub>L</sub>	= 10V,		150		ns
DS1632	2/DS3632							
ICC(0)	Supply Currents		V <sub>CC</sub> = 5V, V <sub>IN</sub> = 5V			8	12	mA
		(Figure 4)	V <sub>CC</sub> = 15V, V <sub>IN</sub> = 15V	Output Low		18	23	mA
<sup>1</sup> CC(1)	, , , , , , , , , , , , , , , , , , , ,	V <sub>IN</sub> = 0V, (Figure 4)	V <sub>CC</sub> = 5V	Output High		2.5	3.5	mA
		VIN - UV, (Figure 4)	V <sub>CC</sub> = 15V	Output High		9	14	mA
tPD1	Propagation to "1"	$V_{CC} = 5V$ , $T_A = 25^{\circ}C$ , (Figure 5)	CL = 15 pF, RL = 50Ω, V <sub>L</sub>	_= 10V,		150		ns
tPD0	Propagation to "0"	V <sub>CC</sub> = 5V, T <sub>A</sub> = 25°C, (Figure 5)	CL = 15 pF, RL = 50Ω, V <sub>L</sub>	_ = 10V,		150		ns
DS1633	3/DS3633							
ICC(0)	Supply Currents	N 01 (5)	V <sub>CC</sub> = 5V			7.5	12	mA
,		V <sub>IN</sub> = 0V, (Figure 4)	V <sub>CC</sub> = 15V	Output Low		16	23	mA
ICC(1)		/F: 41	V <sub>CC</sub> = 5V, V <sub>IN</sub> = 5V			2	4	mΑ
		(Figure 4)	V <sub>CC</sub> = 5V, V <sub>IN</sub> = 5V V <sub>CC</sub> = 15V, V <sub>IN</sub> = 15V	Output High	,	7.2	15	mA
<sup>†</sup> PD1	Propagation to "1"	V <sub>CC</sub> = 5V T <sub>A</sub> = 25°C, (Figure 5)	C <sub>L</sub> = 15 pF, R <sub>L</sub> = 50Ω, V <sub>L</sub>	= 10V,		200		ns
tPD0	Propagation to "O"	V <sub>CC</sub> = 5V, T <sub>A</sub> = 25°C, ( (Figure 5)	$C_L = 15 pF, R_L = 50\Omega, V_L$	= 10V,	-	150	-	ns

### Electrical Characteristics (Continued)

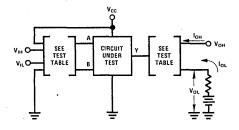
1	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS	
DS1634/	DS3634							
ICC(0)	Supply Currents	(Figure 4)	V <sub>CC</sub> = 5V, V <sub>IN</sub> = 5V	Output Low		7.5	12	mA
		V <sub>CC</sub> = 15V, V <sub>IN</sub> = 15V		18	23	mA		
ICC(1)		V <sub>IN</sub> = 0V, (Figure 4)	V <sub>CC</sub> = 5V	Output High		3	5	mA
		V <sub>1N</sub> = 0V, (Figure 4)	V <sub>CC</sub> = 15V	Output riigii		11	18	, mA
tPD1	Propagation to "1"	$V_{CC} = 5V$ , $T_A = 25^{\circ}C$ , $C_L = 15 pF$ , $R_L = 50\Omega$ , $V_L = 10V$ , (Figure 5)			150		ns	
<sup>t</sup> PD0	Propagation to "0"	$V_{CC} = 5V$ , $T_A = 25^{\circ}C$ , $C_L = 15 pF$ , $R_L = 50\Omega$ , $V_L = 10V$ , (Figure 5)			150		ns	

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DS1631, DS1632, DS1633 and DS1634 and across the 0°C to +70°C range for the DS3631, DS3632, DS3633 and DS3634. All typical values are for TA = 25°C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

#### **Test Circuits**



CIRCUIT	INPUT UNDER	OTHER	ruo	PUT
Cincorr	TEST	INPUT	APPLY	MEASURE
DS3631	VIH	V <sub>IH</sub>	IOH	VOH
	VIL	V <sub>CC</sub>	IOL	VOL
DS3632	VIH	V <sub>IH</sub>	IOL	VoL
	VIL	V <sub>CC</sub>	IOH	VoH
DS3633	VIH	GND	IOH	VOH
	VIL	VIL	IOL	VOL
DS3634	V <sub>IH</sub> V <sub>IL</sub>	GND VIL	I <sub>OL</sub>	V <sub>OL</sub> Voн

Note: Each input is tested separately.

FIGURE 1. VIH, VIL, VOH, VOL

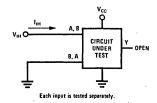
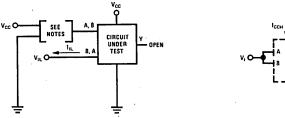


FIGURE 2. I<sub>1H</sub>

## Test Circuits (Continued)



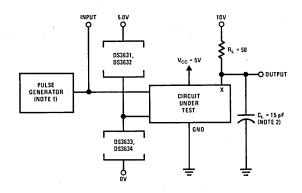
Note A: Each input is tested separately. Note B: When testing DS1633 and DS1634 input not under test is grounded. For all other circuits it is at  $V_{CC}$ .

Both gates are tested simultaneously.

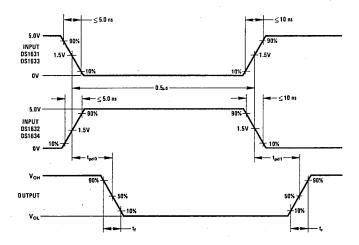
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FIGURE 3. IIL

FIGURE 4. ICC



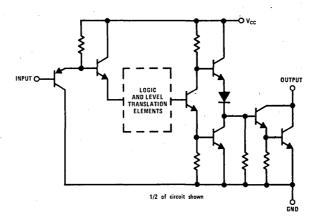
## **Switching Time Waveforms**



Note 1: The pulse generator has the following characteristics: PRR = 500 kHz,  $Z_{OUT} \approx 50\Omega$ . Note 2:  $C_L$  includes probe and jig capacitance.

FIGURE 5. Switching Times.

## Schematic Diagram (Equivalent Circuit)





## **DS3654 Printer Solenoid Driver**

## **General Description**

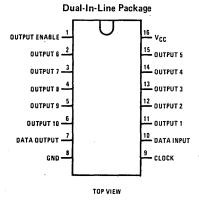
The DS3654 is a serial-to-parallel 10-bit shift register with a clock and data input, a data output from the tenth bit, and 10 open-collector clamped relay driver outputs suitable for driving printer solenoids.

Timing for the circuit is shown in Figure 1. Data input is sampled on the positive clock edge. Data output changes on the negative clock edge, and is always active. Enable transfers data from the shift register to the open-collector outputs. Internal circuitry inhibits output enable for power supply voltage less than 6V.

Peripheral/Power Drivers

Each output sinks 250 mA and is internally clamped to ground at 50V to dissipate energy stored in inductive

## **Connection Diagram**

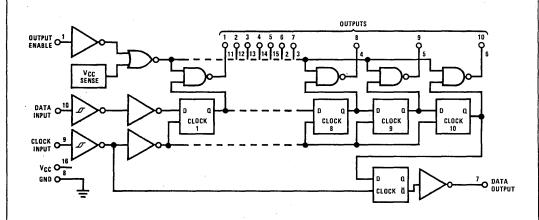


Order Number DS3654J or DS3654N See NS Package J16A or N16A

#### Pin Descriptions

Pin No.	Function
1	Output Enable
2	Output 6
3	Output 7
4	Output 8
5	Output 9
6	Output 10
7	Data Output
8	Ground
9	Clock Input
10	Data Input
11	Output 1
12	Output 2
13	Output 3
14	Output 4
15	Qutput 5
16	Vcc

## Logic Diagram



<b>Absolute Maximum Ra</b>	Operating Conditions					
			MIN	MAX	UNITS	
Supply Voltage, VCC	9.5V max	Supply Voltage (VCC)	7.5	9.5	٧	
Input Voltage	-0.5V min, 9.5V max	Temperature (T <sub>A</sub> )	0	+70	· °c	
Output Supply, Vp-p	·45V max	Output Supply (Vp-p)		40	V	
Storage Temperature Range	–65°C to +150°C	Cathat Sappiy (VP P)	•	40	. •	
Output Current (Single Output)	0.4A					
Ground Current	4.0A					
Peak Power Dissipation t < 10 ms,	4.5W Max					
Duty Cycle < 5%		•				
Maximum Power Dissipation* at 25°C			*			
Cavity Package	1635 mW					
Molded Package	1687 mW					
Lead Temperature (Soldering, 10 seconds)	300° C		•			
*Derate cavity package 10.9 mW/°C above	3E <sup>O</sup> Co donoto modelad		: .			
package 13.5 mW/°C above 25°C.	25 C; derate molded					

## Electrical Characteristics (Notes 2, 3 and 4) Vp-p = 30V unless otherwise noted

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
Logical "1" Input Voltage		2.6			V
Logical "0" Input Voltage		:		0.8	V
Logical "1" Output Voltage Clamp	ICLAMP = 0.1A, VEN = 0V	45	50	65	v
Logical "1" Output Current	V <sub>OH</sub> = 40V, V <sub>EN</sub> = 0			1.0	mA
Logical "0" Output Voltage	IOL = 250 mA, V <sub>EN</sub> = 2.6V			1.6	V
Logical "1" Input Current		·			
Clock	T <sub>A</sub> = 70°C, V <sub>CL</sub> = 2.6V	0.2	0.33		mA.
Enable	T <sub>A</sub> = 70°C, V <sub>EN</sub> = 2.6V	0.2	0.33	. 1	. mA
Data	$T_A = 70^{\circ}C, V_D = 2.6V$	0.3	0.57		mA
Clock	T <sub>A</sub> = 0°C, V <sub>CL</sub> = 2.6V		0.33	0.5	mA
Enable	$T_A = 0^{\circ}C, V_{EN} = 2.6V$		0.33	0.5	mA
Data	$T_A = 0^{\circ}C, V_D = 2.6V$	ļ	0.57	0.75	mA
ogical "0" Input Current					
Clock	T <sub>A</sub> = 70°C, V <sub>CL</sub> = 1V		125		μΑ
Enable	$T_A = 70^{\circ} C, V_{EN} = 1V$		125		μΑ
'Data'	$T_A = 70^{\circ}C, V_D = 1V$		220	1	μΑ
Input Pull-Down Resistance					
Clock	$T_A = 25^{\circ}C$ , $V_{CL} < V_{CC}$	İ	8		kΩ
Enable	T <sub>A</sub> = 25°C, V <sub>EN</sub> < V <sub>CC</sub>	<u> </u>	8		kΩ
Data	$T_A = 25^{\circ}C$ , $V_D < V_{CC}$	j	4.5		kΩ
Supply Current (ICC)				,	
Outputs Disabled	$T_A \ge 25^{\circ}C$ , $V_{EN} = 0$ , $V_{DO} = 0$ , $V_{CC} = 9.5V$		27	40	mA
Outputs Enabled	$T_A \ge 25^{\circ}$ C, $V_{EN} = 2.6$ , $I_{OL} = 250 \text{ mA}$ Each Bit		55	70	m <i>P</i>
Data Output Low (VDOL)	V <sub>D</sub> = 0, I <sub>OL</sub> = 0		0.01	0.5	٧
Data Output High (VDOH)	V <sub>D</sub> = 2.6, I <sub>OH</sub> = -0.75 mA	2.6	3.4		· . V
Data Output Pull-Down Resistance	V <sub>D</sub> = 0, V <sub>DO</sub> = 1V		14		kΩ

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the  $0^{\circ}$ C to +70°C temperature range and the 7.5V to 9.5V power supply range. All typical values given are for  $V_{CC}$  = 8.5V and  $T_{A}$  = 25°C.

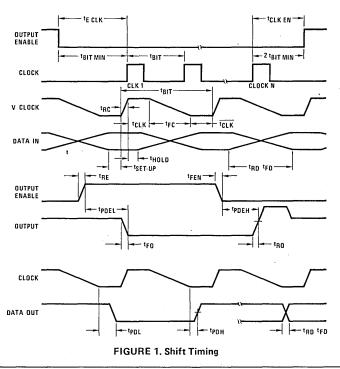
Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise specified.

Note 4: Only one output at a time should be shorted.

## **Switching Characteristics** 0°C to +70°C, T<sub>A</sub> = 25°C, nominal power supplies unless otherwise noted

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
Clk, Data and Enable Inputs	(Figure 1)				
tFC				2.0	μs
tRC	$t_{BIT} \geq 10~\mu s$	1		2.0	μs
tCLK		2			μs
†CLK		3.5			μs
tHOLD				1.0	μs
tSET-UP				1.0	μs
tre, trdin			}	1.0	μs
tfe, tfD IN				5.0	μs
Output 1–10	Vp-p = 20V				
<sup>t</sup> RO	$R_L = 100\Omega, C_L < 100 pF$		1.2		μs
tFO	R <sub>L</sub> = 100Ω, C <sub>L</sub> < 100 pF		1.2		μs
tPDEH .	,	1	3.5		μς
tPDEL			3.0		μs
Data Output					
tPDH, tPDL	RL = $5 k\Omega$ , CL $\leq 10 pF$		0.8	2.5	μs
tRD			0.4		μs
tFD	·		0.4		μs
Clock to Enable Delay					
<sup>†</sup> CE		2 tBIT			μs
Enable to Clock Delay		tBIT			μs

## **Switching Time Waveforms**



## **Definition of Terms**

Vp-p: Output power supply voltage. The return for open-collector relay driver outputs.

tBIT: Period of the incoming clock.

VCLK: The voltage at the clock input.

tclk: The portion of tBIT when  $V_{CLK} \ge 2.6V$ .

TCLK: The portion of tBIT when VCLK ≤ 0.8V

**tset-up:** The time prior to the end of  $\overline{\text{tclk}}$  required to insure valid data at the shift register input for subsequent clock transitions.

 $t_{\mbox{HOLD}}.$  The time following the start of  $t_{\mbox{CLK}}$  required to transfer data within the shift register.

## National Semiconductor

## **DS3656 Quad Peripheral Driver**

## **General Description**

The DS3656 is a quad peripheral driver designed for use in automotive applications. Logically it is an open collector NAND function with all inputs compatible with 74LS and CMOS series products. An enable input is provided that is common to each driver. When taken to a logic zero level all outputs will turn off. Also, overvoltage is detected.

The DS3656 has features associated with the output structure that make it highly versatile to many applications. Each output is capable of 600 mA sink currents and offers 65V standoff voltage in non-inductive applications. A clamp network capable of handling 800 mA is incorporated in each output which eliminates the need of an external network to quench the high voltage backswing caused when switching inductive loads up to 30V (reference AN-213).

The DS3656 is intended to operate from a 12V automotive battery. Internal to the device is its own voltage regulator which permits the device to operate during the wide voltage variation seen in many automotive applications. An overvoltage-protection circuit is incorporated that will cause the outputs to turn off when the supply exceeds 30V. The circuit is designed to withstand worst case fault conditions that occur in automotive applications, such as

high voltage transients and reverse battery connection. In this type of environment an external  $100\Omega$  resistor must be

**Peripheral/Power Drivers** 

The molded package is specifically constructed to allow increased power dissipation over conventional packages. The four ground pins are directly connected to the device chip with a special copper lead frame. When the quad driver is soldered into a copper PC board the power rating of the device will significantly improve.

#### **Features**

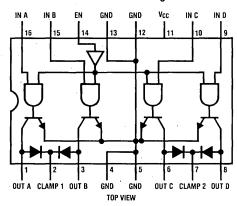
Quad automotive peripheral driver

connected in series with the V<sub>CC</sub> line.

- 600 mA output current capability
- High voltage outputs 65V
- Clamp diode provided for inductive loads
- Built in regulator
- Overvoltage failsafe
- TTL/LS/CMOS compatible diode clamped inputs
- High power dissipation package
- Guaranteed to withstand worst case fault conditions

## Connection Diagram

#### Dual-In-Line Package



Order Number DS3656N See NS Package N16A

## **Truth Table**

Enable	In X	Out X
Н	Н	L
н	L	н
L	. <b>X</b>	н

H = high level L = low level X = irrelevant

#### Absolute Maximum Ratings (Note 1) **Operating Conditions** Supply Voltage, V<sub>CC</sub> (Note 2) 65V Max Units Input Voltage 7V Supply Voltage, V<sub>CC</sub> 17.0 10.5 **Output Voltage** 65V Temperature - 40 105 °C Continuous Output Current 1.2A **Junction Temperature** 150°C Thermal Resistance (Junction to Ambient) DS3656N Plugged in a Socket 60°C/W DS3656N Soldered in a PC Board 35°C/W DS3656N Soldered in a PC Board 20°C/W with 6 in<sup>2</sup> Cn Foil Lead Temperature (Soldering, 10 seconds) 300°C

### Electrical Characteristics (Notes 2 and 3)

Symbol	Parameter	Conditions	Min	Max	Units
V <sub>CC</sub>	Power Supply Voltage	,	10.5	17	V
l <sub>cc</sub>	Power Supply Current			65	mA
$V_{tH}$	High Level Input Voltage		2.0		V
V <sub>IL</sub>	Low Level Input Voltage			0.8	٧
Iн	High Level Input Current	V <sub>IN</sub> = 2.7V		20	μА
l <sub>IL</sub>	Low Level Input Current	$V_{IN} = 0.4V$		- 360	μΑ
V <sub>ICL</sub>	Input Clamp Voltage	I <sub>IN</sub> = -10 mA		- 1.5	٧
V <sub>OL</sub>	Low Level Output Voltage	$I_L = 600 \text{ mA}, V_{CC} = 10.5V$		1.5	٧
l <sub>он</sub>	High Level Leakage Current	V <sub>OH</sub> = 65V		1.0	. mA
V <sub>F</sub>	Output Diode Forward Voltage	I <sub>F</sub> = 800 mA		2.5	٧
I <sub>R</sub>	Output Diode Reverse Leakage	V <sub>R</sub> =65V		1.0	mA
B <sub>VCER</sub>	V <sub>OH1</sub> Switching Capacitive or Resistive Load			65	٧
L <sub>VCEO</sub>	V <sub>OH2</sub> Switching Inductive Clamped Load			30	V

## Switching Characteristics $V_{CC} = 13.2V$ , $T_A = 25$ °C

Symbol	Parameter	Conditions	Min	Max	Units
t <sub>PLH</sub>	Propagation Delay Time Low to High Level Output	$V_{CC} = 13.2V, R_L = 30\Omega, C_L = 15 pF$		10	μS
t <sub>PHL</sub>	Propagation Delay Time High to Low Level Output	$V_{CC} = 13.2V, R_L = 30\Omega, C_L = 15 pF$		10	μS
t <sub>TLH</sub>	Transition Time Low to High Level Output	$V_{CC} = 13.2V, R_L = 30\Omega, C_L = 15 pF$		500	ns
t <sub>THL</sub>	Transition Time High to Low Level Output	$V_{CC} = 13.2V, R_L = 30\Omega, C_L = 15 pF$		500	ns
t <sub>PLH</sub>	Enable to Output	$V_{CC} = 13.2V, R_L = 30\Omega, C_L = 15 pF$		10	μS
t <sub>PHL</sub>	Enable to Output	$V_{CC} = 13.2V, R_L = 30\Omega, C_L = 15 pF$		10	μS

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Voltage values are with respect to network ground terminal unless otherwise specified.

Note 3: Unless otherwise specified min/max limits apply across the -40°C to +105°C temperature range.



## **DS3658 Quad High Current Peripheral Driver**

## **General Description**

The DS3658 quad peripheral driver is designed for those applications where low operating power, high breakdown voltage, high output current and low output ON voltage are required. A unique input circuit combines TTL compatibility with high impedance. In fact, its extreme low input current allows it to be driven directly by a CMOS device.

The outputs are capable of sinking 600 mA each and offer a 70V breakdown. However, for inductive loads the output should be clamped to 35V or less to avoid latch-up during turn off (inductive fly back protection—refer AN-213). An on-chip clamp diode capable of handling 800 mA is provided at each output for this purpose. In addition, the DS3658 incorporates circuitry that guarantees glitch-free power up or down operation and a fail-safe feature which puts the output in a high impedance state when input is open.

The molded package is specifically constructed to allow increased power dissipation over conventional packages. The four ground pins are directly connected to the device chip with a special copper lead frame. When the quad driver is soldered into a PC board, the power rating of the device improves significantly.

#### **Applications**

- Relay drivers
- Lamp drivers
- Solenoid drivers
- Hammer drivers
- Stepping motor drivers
- Triac drivers

- LED drivers
- High current, high voltage drivers
- Level translators
- Fiber optic LED drivers

#### **Features**

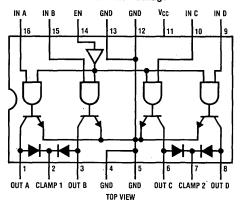
- Single saturated transistor outputs
- Low standby power, 10 mW typical
- High impedance TTL compatible inputs
- Outputs may be tied together for increased current capacity

**Peripheral/Power Drivers** 

- High output current 600 mA per output 2.4A per package
- No output latch-up at 35V
- Low output ON voltage (350 mV typ @ 600 mA)
- High breakdown voltage (70V)
- Open collector outputs
- Output clamp diodes for inductive fly back protection
- NPN inputs for minimal input currents (1 μA typical)
- Low operating power
- Standard 5V power supply
- Power up/down protection
- Fail safe operation
- 2W power package
- Pin-for-pin compatible with SN75437

## **Connection Diagram**

#### Dual-In-Line Package



Order Number DS3658N See NS Package N16A

## **Truth Table**

IN	EN	OUT
Н	Н	L
L	Н	Z
H	L	Z
L	L	Z

H = High state

L = Low state

Z = High impedance state

#### Absolute Maximum Ratings (Note 1) **Operating Conditions** Max 7.07 Supply Voltage 4.75 Supply Voltage 5.25

**Ambient Temperature** 

Units

°C

70

Input Voltage 15V **Output Voltage** 70V **Output Current** 1.5A Continuous Power Dissipation @ 25°C Free-Air (Note 5) 2075 mW

-65°C to +150°C

300°C

## Electrical Characteristics (Notes 2 and 3)

Storage Temperature Range

Lead Temperature (Soldering, 10 seconds)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	Input High Voltage		2.0			٧
V <sub>IL</sub>	Input Low Voltage				0.8	V
I <sub>IH</sub>	Input High Current	V <sub>IN</sub> = 5.25V, V <sub>CC</sub> = 5.25V		1.0	10	μΑ
I <sub>IL</sub>	Input Low Current	V <sub>IN</sub> = 0.4V			± 10	μΑ
V <sub>IK</sub>	Input Clamp Voltage	I <sub>I</sub> = -12 mA		- 0.8	- 1.5	· v
V <sub>OL</sub>	Output Low Voltage	I <sub>L</sub> = 300 mA		0.2	0.4	V
	1	I <sub>L</sub> = 600 mA (Note 4)	١	0.35	0.7	V
I <sub>CEX</sub>	Output Leakage Current	$V_{CE} = 70V, V_{IN} = 0.8V$			100	μΑ
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 800 mA		1.0	1.6	V
IR	Diode Leakage Current	V <sub>R</sub> = 70V			100	μΑ
Icc	Supply Current	All Inputs High		50	65	mA
	1	All Inputs Low		2	4	mA

## **Switching Characteristics** (Note 2)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t <sub>HL</sub>	Turn On Delay	$R_L = 60\Omega$ , $V_L = 30V$		226	500	ns
t <sub>LH</sub>	Turn Off Delay	$R_L = 60\Omega, V_L = 30V$		2430	8000	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

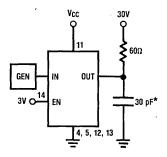
 $\textbf{Note 2:} \ \ \textbf{Unless otherwise specified, min/max limits apply across the 0°C to +70°C temperature range and the 4.75V to 5.25V power supply range. All typical temperature range and the 4.75V to 5.25V power supply range. All typical temperature range and the 4.75V to 5.25V power supply range. All typical temperature range and the 4.75V to 5.25V power supply range. All typical temperature range and the 4.75V to 5.25V power supply range. All typical temperature range and the 4.75V to 5.25V power supply range. All typical temperature range and the 4.75V to 5.25V power supply range. All typical temperature range and the 4.75V to 5.25V power supply range. All typical temperature range are the 4.75V to 5.25V power supply range. All typical temperature range are the 4.75V to 5.25V power supply range. All typical temperature range are the 4.75V to 5.25V power supply range. All typical temperature range are the 4.75V to 5.25V power supply range. All typical temperature range are the 4.75V to 5.25V power supply range. All typical temperature range are the 4.75V to 5.25V power supply range. All typical temperature range are the 4.75V to 5.25V power supply range. All the 4.7$ values are for  $T_A = 25$ °C and  $V_{CC} = 5.0V$ .

Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max or min are so classified on absolute value basis.

Note 4: All sections of this quad circuit may conduct rated current simultaneously; however, power dissipation averaged over a short interval of time must fall within specified continuous dissipation ratings.

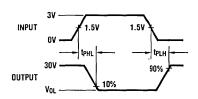
Note 5: For operation over 25°C free-air temperature, derate linearly to 1328 mW @70°C @ the rate of 16.6 mW/°C.

## **AC Test Circuit**



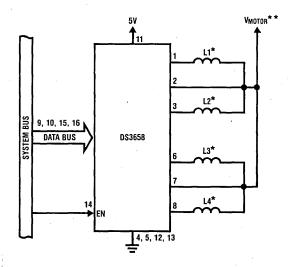
<sup>\*</sup> Includes probe and jig capacitance

## **Switching Waveforms**



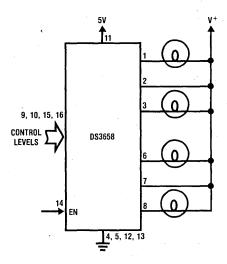
## **Typical Applications**

**Stepping Motor Driver** 



- \* L1, L2, L3, L4 are the windings of a bifilar stepping motor.
- \*\* V<sub>MOTOR</sub> is the supply voltage of the motor.

#### Lamp Driver





## Peripheral/Power Drivers

## **DS3668 Quad Fault Protected Peripheral Driver**

#### **General Description**

The DS3668 quad peripheral driver is designed for those applications where low operating power, high breakdown voltage, high output current and low output ON voltage are required. Unlike most peripheral drivers available, a unique fault protection circuit is incorporated on each output. When the load current exceeds 1.0 A (approximately) on any output for more than a built-in delay time, nominally 25 µs, that output will be shut off by its protection circuitry with no effect on other outputs. This condition will prevail until that protection circuitry is reset by toggling the corresponding input or the enable pin low for at least 0.5 µs. The 25 µs built-in delay is provided to ensure that the protection circuitry is not triggered by turn-on surge currents associated with certain kinds of loads.

The DS3668's inputs combine TTL compatibility with high input impedance. In fact, its extreme low input current allows it to be driven directly by a MOS device. The outputs are capable of sinking 600 mA each and offer a 70V breakdown. However, for inductive loads the output should be clamped to 35V or less to avoid latch up during turn off (inductive fly-back protection — refer AN-213). An on-chip clamp diode capable of handling 800 mA is provided at each output for this purpose. In addition, the DS3668 incorporates circuitry that guarantees glitch-free power up or down operation and a fail-safe feature which puts the output in a high impedance state when the input is open.

The molded package is specifically constructed to allow increased power dissipation over conventional packages. The four ground pins are directly connected to the device chip with a special copper lead frame. When the quad driver is soldered into a PC board, the power rating of the device improves significantly.

#### **Applications**

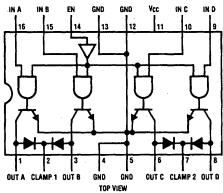
- Relay drivers
- Solenoid drivers -
- Hammer drivers
- Stepping motor drivers
- Triac drivers
- LED drivers
- High current, high voltage drivers
- Level translators
- Fiber optic LED drivers

#### **Features**

- Output fault protection
- High impedance TTL compatible inputs
- High output current 600 mA per output
- No output latch-up at 35V
- Low output ON voltage (550 mV typ @ 600 mA)
- High breakdown voltage (70V)
- Open collector outputs
- Output clamp diodes for inductive fly-back protection
- NPN inputs for minimal input currents (1 µA typical)
- Low operating power
- Standard 5V power supply
- Power up/down protection
- Fail-safe operation
- 2W power package
- Pin-for-pin compatible with SN75437

## **Connection Diagram\***

#### **Dual-In-Line Package**



TL/F/5225-1

## **Truth Table**

IN	EN	OUT
н	Ξ	L
L	H ·	Z
н	L	Z
L	L	Z

H=High state

L=Low state

Z = High impedance state

Order Number DS3668N See NS Package N16A

<sup>\*</sup> See Page 3 for the detail of output protection.

Units

Max

5.25 70

Absolute Maximum Ratings (Note 1)		Operating Conditio		
Supply Voltage	7.0V		Min	
Input Voltage	15V	Supply Voltage	4.75	
Output Voltage	70V	Ambient Temperature	0	
Continuous Power Dissipation @25°C Free-Air (Note 5)	2075 mW			
Storage Temperature Range	-65°C to +150°C			

300°C

#### Electrical Characteristics (Notes 2 and 3)

Lead Temperature (Soldering, 10 seconds)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	Input High Voltage		2.0			V
V <sub>IL</sub>	Input Low Voltage				0.8	V
lн	Input High Current	V <sub>IN</sub> = 5.25V, V <sub>CC</sub> = 5.25V		1.0	20	μΑ
I <sub>IL</sub>	Input Low Current	V <sub>IN</sub> =0.4V		-	±10	μΑ
VIK	Input Clamp Voltage	I <sub>I</sub> = -12 mA		-0.8	-1.5	V
V <sub>OL</sub>	Output Low Voltage	I <sub>L</sub> = 300 mA		0.2	0.7	V
		I <sub>L</sub> =600 mA (Note 4)		0.55	1.5	V
ICEX	Output Leakage Current	V <sub>CE</sub> =70V, V <sub>IN</sub> =0.8V			100	μА
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> =800 mA		1.2		V
I <sub>R</sub>	Diode Leakage Current	V <sub>R</sub> =70V			100	μΑ
lcc	Supply Current	All Inputs High		62	80	mA
		All Inputs Low		20		mA
I <sub>TH</sub>	Protection Circuit Threshold Current			1		А

#### Switching Characteristics (Note 2)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
tHL	Turn On Delay	$R_L = 60\Omega, V_L = 30V$		300		ns
t <sub>LH</sub>	Turn Off Delay	$R_L = 60\Omega, V_L = 30V$		2000 /		ns
t <sub>FZ</sub>	Protection Enable Delay (after Detection of fault)			25		μs
t <sub>RL</sub>	Input Low Time For Protection Circuit Reset		1.0			μs

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the 0°C to +70°C temperature range and the 4.75V to 5.25V power supply range. All typical values are for  $T_A = 25$ °C and  $V_{CC} = 5.0$ V.

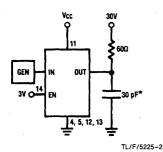
Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max or min are so classified on absolute value basis.

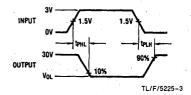
Note 4: All sections of this quad circuit may conduct rated current simultaneously; however, power dissipation averaged over a short interval of time must fall within specified continuous dissipation ratings.

Note 5: For operation over 25°C free-air temperature, derate linearly to 1328 mW @ 70°C @ the rate of 16.6 mW/°C.

#### **AC Test Circuit**

#### **Switching Waveforms**

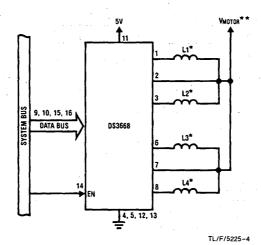




\*Includes probe and jig capacitance

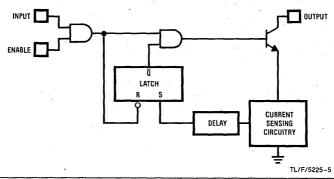
#### **Typical Application**

#### **Stepping Motor Driver**



\*L1, L2, L3, L4 are the windings of a bifilar stepping motor.

# **Protection Circuit Block Diagram**



<sup>\*\*</sup>V<sub>MOTOR</sub> is the supply voltage of the motor.



# Peripheral/Power Drivers PRELIMINARY

# **DS3669 Quad High Current Peripheral Driver**

#### **General Description**

The DS3669 is a non-inverting quad peripheral driver similar to the DS3658. These drivers are designed for those applications where low operating power, high breakdown voltage, high output current and low output ON voltage are required. A unique input circuit combines TTL compatibility with high impedance. In fact, its extreme low input current allows it to be driven directly by a CMOS device.

The outputs are capable of sinking 600 mA each and offer a 70V breakdown. However, for inductive loads the output should be clamped to 35V or less to avoid latch-up during turn off (inductive fly back protection—refer AN-213). An on-chip clamp diode capable of handling 800 mA is provided at each output for this purpose. In addition, the DS3669 incorporates circuitry that guarantees glitch-free power up or down operation.

The molded package is specifically constructed to allow increased power dissipation over conventional packages. The four ground pins are directly connected to the device chip with a special copper lead frame. When the quad driver is soldered into a PC board, the power rating of the device improves significantly.

#### **Applications**

- Relay drivers
- Lamp drivers
- Solenoid drivers
- Hammer drivers

- Stepping motor drivers
- Triac drivers
- LED drivers
- High current, high voltage drivers
- Level translators
- Fiber optic LED drivers

#### **Features**

- Single saturated transistor outputs
- Low standby power, 10 mW typical
- High impedance TTL compatible inputs
- Outputs may be tied together for Increased current capacity
- High output current 600 mA per output 2.4A per package
- No output latch-up at 35V
- Low output ON voltage (350 mV typ @ 600 mA)
- High breakdown voltage (70V)
- Open collector outputs
- Output clamp diodes for inductive fly back protection
- NPN inputs for minimal input currents (1 µA typical)
- Low operating power
- Standard 5V power supply
- Power up/down protection
- 2W power package

#### **Connection Diagram**

# Dual-In-Line Package IN A IN B EN GND GND Vcc IN C IN D 16 15 14 13 12 111 10 9 1 2 3 4 5 6 7 8 OUT A CLAMP 1 OUT B GND GND OUT C CLAMP 2 OUT D

Order Number DS3669N See NS Package N16A

#### **Truth Table**

	IN	EN	OUT
ĺ	٦	Н	L
ı	Н	Н	Z
	L	L	Z
	Н	L	Z

H = High state

L = Low state

Z = High impedance state

#### Absolute Maximum Ratings (Note 1)

#### **Operating Conditions**

			Min	Max	Units
Supply Voltage	7.0V	Supply Voltage	4.75	5.25	V
Input Voltage	15V	Ambient Temperature	0	70	°C
Output Voltage	70V				
Output Current	1.5A				
Continuous Power Dissipation @ 25°C Free-Air (Note 5)	2075 mW				
Storage Temperature Range	-65°C to +150°C				
Lead Temperature (Soldering, 10 second	nds) 300°C				

#### Electrical Characteristics (Notes 2 and 3)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	Input High Voltage		2.0			V
VIL	Input Low Voltage	,			0.8	V
Iн	Input High Current	V <sub>IN</sub> = 5.25V, V <sub>CC</sub> = 5.25V		1.0	10	μА
IIL	Input Low Current	$V_{IN} = 0.4V$			± 10	μА
V <sub>IK</sub>	Input Clamp Voltage	$I_1 = -12 \text{ mA}$		- 0.8	- 1.5	V
V <sub>OL</sub>	Output Low Voltage	I <sub>L</sub> = 300 mA		0.2	0.4	V
		I <sub>L</sub> = 600 mA (Note 4)		0.35	0.7	V
I <sub>CEX</sub>	Output Leakage Current	$V_{CE} = 70V, V_{IN} = 2V,$ $V_{EN} = 0.8V$			100	μΑ
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 800 mA		1.0	1.6	· V
1 <sub>R</sub>	Diode Leakage Current	V <sub>R</sub> = 70V			100	μΑ
I <sub>CC</sub>	Supply Current	All Inputs Low EN = 2.0V		50	65	. mA
		All Inputs High		2	4	mA

#### Switching Characteristics (Note 2)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t <sub>HL</sub>	Turn On Delay	$R_L = 60\Omega, V_L = 30V$		226	500	ns
t <sub>LH</sub>	Turn Off Delay	$R_L = 60\Omega, V_L = 30V$		2430	8000	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

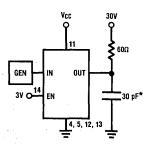
Note 2: Unless otherwise specified, min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C temperature range and the 4.75V to 5.25V power supply range. All typical values are for  $T_A = 25^{\circ}$ C and  $V_{CC} = 5.0$ V.

Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max or min are so classified on absolute value basis.

Note 4: All sections of this quad circuit may conduct rated current simultaneously; however, power dissipation averaged over a short interval of time must fall within specified continuous dissipation ratings.

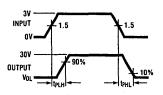
Note 5: For operation over 25°C free-air temperature, derate linearly to 1328 mW @70°C @ the rate of 16.6 mW/°C.

#### **AC Test Circuit**



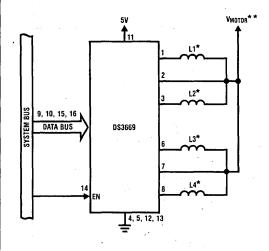
\*Includes probe and jig capacitance

#### **Switching Waveforms**



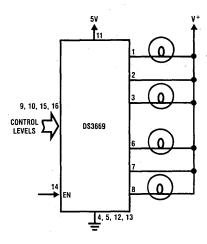
#### **Typical Applications**

#### **Stepping Motor Driver**



- \*L1, L2, L3, L4 are the windings of a bifilar stepping motor.
- \*\* V<sub>MOTOR</sub> is the supply voltage of the motor.

#### Lamp Driver



### **Peripheral/Power Drivers**

# **DS3680 Quad Negative Voltage Relay Driver**

#### **General Description**

The DS3680 is a quad high voltage negative relay driver designed to operate over wide ranges of supply voltage, common-mode voltage, and ambient temperature, with 50 mA sink capability. These drivers are intended for switching the ground end of loads which are directly connected to the negative supply, such as in telephone relay systems.

Since there may be considerable noise and IR drop between logic ground and negative supply ground in many applications, these drivers are designed to operate with a high common-mode range (±20V referenced to negative supply ground). Each driver has a common-mode range separate from the other drivers in the package, which permits input signals from more than one element of the system.

With low differential input current requirements (typically 100  $\mu$ A), these drivers are compatible with TTL, LS and CMOS logic. Differential inputs permit either inverting or non-inverting operation.

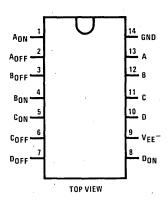
The driver outputs incorporate transient suppression clamp networks, which eliminate the need for external networks when used in applications of switching inductive loads. A fail-safe feature is incorporated to insure that, if the  $V_{\mbox{\scriptsize ON}}$  input or both inputs are open, the driver will be OFF.

#### **Features**

- -10V to -60V operation
- Quad 50 mA sink capability
- TTL/LS/CMOS or voltage comparator input
- High input common-mode voltage range
- Very low input current
- Fail-safe disconnect feature
- Built-in output clamp diode

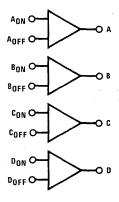
#### **Connection Diagram**

#### **Dual-In-Line Package**



Order Number DS3680J or DS3680N See NS Package J14A or N14A

#### **Logic Diagram**



#### Absolute Maximum Ratings (Note 1)

Supply Voltage: GND to VEE , and Any P	in – 70V
Positive Input Voltage: Input to GND	20V
Negative Input Voltage: Input to VEE	- 5V
Differential Input Voltage: Von to Voff	± 20V
Inductive Load	L <sub>L</sub> ≤5h
	ار≤50 mA
Output Current	– 100 mA
Storage Temperature	-65°C to +150°C
Maximum Power Dissipation* at 25°C	
Cavity Package	1433 mW
Molded Package	1398 mW
Lead Temperature (Soldering, 10 second	s) 300°C

#### **Recommended Operating Conditions**

Min	Max	Units
<b>– 10</b>	<b>- 60</b>	V
-20	20	V
2	20	٧
20	0.8	٧
- 25	85	°C
	- 10 - 20 2 - 20	- 10

#### Electrical Characteristics (Notes 2 and 3)

\*Derate cavity package 9.6 mW/\*C above 25\*C; derate molded package

11.2 mW/°C above 25°C.

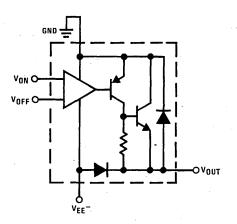
	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	Logic "1" Input Voltage	,	2.0	1.3		v
VIL	Logic "0" Input Voltage			1.3	0.8	v
I <sub>INH</sub>	Logic "1" Input Current	V <sub>IN</sub> = 2V V <sub>IN</sub> = 7V		40 375	100 1000	μA μA
I <sub>INL</sub>	Logic "0" Input Current	$V_{IN} = 0.4V$ $V_{IN} = -7V$		- 0.01 - 1	-5 -100	μ <b>Α</b> μ <b>Α</b>
$V_{OL}$	Output ON Voltage	I <sub>OL</sub> = 50 mA		- 1.6	-2.1	v
I <sub>OFF</sub>	Output Leakage	V <sub>OUT</sub> = V <sub>EE</sub> -		- 2	- 100	μΑ
IFS	Fail-Safe Output Leakage	V <sub>OUT</sub> = V <sub>EE</sub> - (Inputs Open)		-2,	-100	μА
ILC	Output Clamp Leakage Current	V <sub>OUT</sub> = GND		2	100	μΑ
V <sub>C</sub>	Output Clamp Voltage	I <sub>CLAMP</sub> = -50 mA Referenced to V <sub>EE</sub>		-2	-1.2	. V
V <sub>P</sub>	Positive Output Clamp Voltage	I <sub>CLAMP</sub> = 50 mA Referenced to GND		0.9	1.2	٧
I <sub>EE(ON)</sub>	ON Supply Current	All Drivers ON		-2	-4.4	mA
I <sub>EE(OFF)</sub>	OFF Supply Current	All Drivers OFF		~1	- 100	μΑ
t <sub>PD(ON)</sub>	Propagation Delay to Driver ON	$L = 1h$ , $R_L = 1k$ , $V_{IN} = 3V$ Pulse		1	10	μS
t <sub>PD(OFF)</sub>	Propagation Delay to Driver OFF	$L = 1h$ , $R_L = 1k$ , $V_{IN} = 3V$ Pulse		1	10	μS

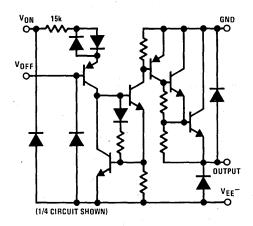
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range", they are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, the min/max limits of the table of "Electrical Characteristics" apply within the range of the table of "Operating Conditions". All typical values are given for VEE = 52V, and TA = 25°C.

Note 3: All current into device plns shown as positive, out of the device as negative. All voltages are referenced to ground unless otherwise noted.

# Schematic Diagrams





# **DS3686 Dual Positive Voltage Relay Driver**

#### **General Description**

The DS3686 is a high voltage/current positive voltage relay driver having many features not available in present relay drivers.

PNP inputs provide both TTL/LS compatibility and high input impedance for low input loading.

Output leakage is specified over temperature at an output voltage of 54V. Minimum output breakdown (ac/ latch breakdown) is specified over temperature at 5 mA. This clearly defines the actual breakdown of the device since the circuit has incorporated in it an internal reference which does not allow output breakdown latching found in existing relay drivers. Additionally, this internal reference circuit feature will eliminate the need in most cases of an external clamping (inductive transient voltage protection) diode. When the output is turned "OFF" by input logic conditions the resulting inductive voltage transient seen at the output is detected by an internal zener reference. The reference then momentarily activates the output transistor long enough so that the relay energy is discharged. This feature eliminates the need of external circuit protection components and insures output transistor protection.

The outputs are Darlington connected transistors, which allow high current operation at low internal VCC

current levels-base drive for the output transistor is obtained from the load in proportion to the required loading conditions. Typical VCC power with both outputs "ON" is 90 mW.

**Peripheral/Power Drivers** 

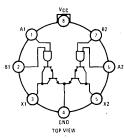
The circuit also features output transistor protection if the VCC supply is lost by forcing the output into the high impedance "OFF" state with the same breakdown levels as when VCC was applied.

#### **Features**

- TTL/LS/CMOS compatible inputs
- High impedance inputs (PNP's)
- High output voltage breakdown (65V typ)
- High output current capability (300 mA max)
- Internal protection circuit eliminates need for output protection diode
- Output breakdown protection if VCC supply is lost
- Low VCC power dissipation (90 mW (typ) both outputs "ON")
- Voltage and current levels compatible for use in telephone relay applications

#### Connection Diagrams

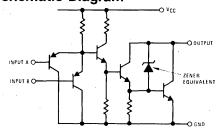
Metal Can Package

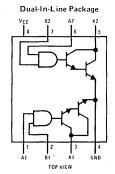


Pin 4 is in electrical contact with the case

Order Number DS3686H See NS Package H08C

#### Schematic Diagram





Order Number DS3686J-8 or DS3686N See NS Package J08A or N08A

#### **Truth Table**

Positive logic: AB = X

А	₿	OUTPUT X
0	0	1
1	0	1
0	1.	1
1.1	1 1	0

Logic "0" output "ON" Logic "1" output "OFF"

#### Absolute Maximum Ratings (Note 1)

#### **Operating Conditions**

Supply Voltage	7V
Input Voltage	15V
Output Voltage	. 56V
Storage Temperature Range	-65°C to +150°C
Maximum Power Dissipation* at 25°C	
Cavity Package	1133 mW
Molded Package	1022 mW
TO-5 Package	787 mW
Lead Temperature (Soldering, 10 seconds)	300°C

#### Electrical Characteristics (Notes 2 and 3)

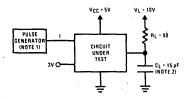
PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	Logical "1" Input Voltage	$R_L = 180\Omega, V_L = 54V, V_O \le 2.5V$	2.0			- V
1 <sub>1H</sub>	Logical "1" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 5.5V		0.01	40	μΑ
VIL	Logical "0" Input Voltage	$R_L = 180\Omega$ , $V_L = 54V$ , $V_O \le 53.8V$			0.8	V
IIL	Logical "0" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V		-150	-250	μΑ
VCD	Input Clamp Voltage	V <sub>CC</sub> = 5V, I <sub>CLAMP</sub> = -12 mA, T <sub>A</sub> = 25°C		-1.0	-1.5	V
Vон	Output Breakdown	VCC = Max, VIN = 0V, IOUT = 5 mA	56	65		V
Іон	Output Leakage	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V, V <sub>OUT</sub> = 54V		0.5	250	μΑ
VOL	Output ON Voltage	V <sub>CC</sub> = Min, DS3686   I <sub>OL</sub> = 100 mA		0.85	1.0	V
		V <sub>IN</sub> = 2.4V D33080 I <sub>OL</sub> = 300 mA		1.0	1.2	V
ICC(1)	Supply Current (Both Drivers)	VCC = Max, VIN = 0V, Outputs Open		2	4	mA
ICC(0)	Supply Current (Both Drivers)	VCC = Max, VIN = 3V, Outputs Open		18	28	mA
tPD0	Propagation Delay to a Logical "0"	$C_L = 15 pF, V_L = 10V, R_L = 50\Omega,$		50		ns
	(Output Turn ON)	T <sub>A</sub> = 25°C, V <sub>CC</sub> = 5V		30	1	"
tPD1	Propagation Delay to a Logical "1"	$C_L = 15 pF, V_L = 10V, R_L = 50\Omega,$		1		
	(Output Turn OFF)	$T_A = 25^{\circ}C$ , $V_{CC} = 5V$		'		μs

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

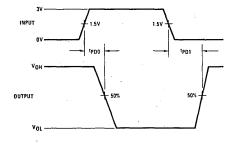
Note 2: Unless otherwise specified min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS3686, All typicals are given for  $V_{CC} = 5V$  and  $T_A = 25^{\circ}$ C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

#### **AC Test Circuit and Switching Time Waveforms**



Note 1: The pulse generator has the following characteristics: PRR = 100 kHz, 50% duty cycle,  $Z_{OUT}\cong 50\Omega$ ,  $t_f=t_f\leq 10$  ns. Note 2:  $C_L$  includes probe and jig capacitance.



 $<sup>\</sup>begin{array}{c|cccc} & \text{MIN} & \text{MAX} & \text{UNITS} \\ \text{Supply Voltage, V}_{CC} & 4.75 & 5.25 & \text{V} \\ \text{Temperature, T}_{A} & 0 & +70 & ^{\circ}\text{C} \end{array}$ 

<sup>\*</sup>Derate cavity package 7.6 mW/°C above 25°C; derate molded package 8.2 mW/°C above 25°C; derate TO-5 package 5.2 mW/°C above 25°C.



# DS1687/DS3687 Negative Voltage Relay Driver

#### General Description

The DS1687/DS3687 is a high voltage/current negative voltage relay driver having many features not available in present relay drivers.

PNP inputs provide both TTL/LS compatibility and high input impedance for low input loading.

Output leakage is specified over temperature at an output voltage of -54V. Minimum output breakdown (ac/ latch breakdown) is specified over temperature at -5 mA. This clearly defines the actual breakdown of the device since the circuit has incorporated in it an internal reference which does not allow output breakdown latching found in existing relay drivers. Additionally, this internal reference circuit feature will eliminate the need in most cases of an external clamping (inductive transient voltage protection) diode. When the output is turned "OFF" by input logic conditions the resulting inductive voltage transient seen at the output is detected by an internal zener reference. The reference then momentarily activates the output transistor long enough so that the relay energy is discharged. This feature eliminates the need of external circuit protection components and insures output transistor protection.

The outputs are Darlington connected transistors, which

allow high current operation at low internal Vcc current levels-base drive for the output transistor is obtained from the load in proportion to the required loading conditions. Typical VCC power with both outputs "ON" is 90 mW.

**Peripheral/Power Drivers** 

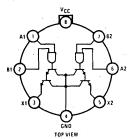
The circuit also features output transistor protection if the VCC supply is lost by forcing the output into the high impedance "OFF" state with the same breakdown levels as when VCC was applied.

#### **Features**

- TTL/LS/CMOS compatible inputs
- High impedance inputs (PNP's)
- High output voltage breakdown (-65V typ)
- High output current capability (300 mA max)
- Internal protection circuit eliminates need for output protection diode
- Output breakdown protection if VCC supply is lost
- Low VCC power dissipation (90 mW (typ) both outputs "ON")
- Voltage and current levels compatible for use in telephone relay applications

#### Connection Diagrams

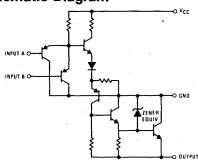
Metal Can Package

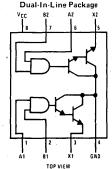


Pin 4 is in electrical contact with the case

Order Number DS1687H or DS3687H See NS Package H08C

#### Schematic Diagram





Order Number DS1687J-8, DS3687J-8 or DS3687N See NS Package J08A or N08A

#### **Truth Table**

Positive logic: AB = X

Α	В	оитрит х
0	0	1
1	0	1
0	1	1
1	1	0

Logic "0" output "ON" Logic "1" output "OFF" Supply Voltage
Input Voltage
Output Voltage
Storage Temperature Range
Maximum Power Dissipation\* at 25°C

Cavity Package Molded Package

TO-5 Package

Lead Temperature (Soldering, 10 seconds)

# Absolute Maximum Ratings (Note 1)

7V
15V
56V
-65°C to +150°C
1133 mW

1022 mW

787 mW 300°C

#### **Operating Conditions**

	MIN	MAX	UNITS
Supply Voltage, VCC			
DS1687	4.5	5.5	٧
DS3687	4.75	5.25	٧
Temperature, TA			
DS1687	-55	+125	°C
DS3687	0	+70	°C

\*Derate cavity package 7.6 mW/°C above 25°C; derate molded package 8.2 mW/°C above 25°C; derate TO-5 package 5.2 mW/°C above 25°C.

#### Electrical Characteristics (Notes 2 and 3)

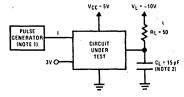
	PARAMETER		CONDIT	IONS	MIN	TYP	MAX	UNITS	
VIH	Logical '1" Input Voltage				2.0			V	
ΊΗ	Logical "1" Input Current	V <sub>CC</sub> = Max,	V <sub>IN</sub> = 5.5	iV .		1.0		μΑ	
VIL	Logical "0" Input Voltage						8.0	V	
IIL	Logical "0" Input Current	V <sub>CC</sub> = Max,	V <sub>IN</sub> = 0.4	V		-150	-250	μΑ	
V <sub>CD</sub>	Input Clamp Voltage	V <sub>CC</sub> = 5V,	CLAMP =	–12 mA, T <sub>A</sub> = 25°C		-1.0	-1.5	٧	
VOH	Output Breakdown	V <sub>CC</sub> = Max,	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0V, I <sub>OUT</sub> = -5 mA		-56	-65		V	
ГОН	Output Leakage	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0V, V <sub>OUT</sub> = -54V			-0.5	-250	μΑ		
VOL	Output ON Voltage		DS1687	I <sub>OL</sub> = -100 mA		-0.9	-1.1	>	
		V <sub>CC</sub> = Min, V <sub>IN</sub> = 2V	V <sub>CC</sub> = Min,	DS1007	IOL = -300 mA		-1.0	-1.3	٧
			DS3687	IOL = -100 mA		-0.9	-1.0	٧	
				I <sub>OL</sub> = -300 mA		-1.0	-1.2	·V	
ICC(1)	Supply Current (Both Drivers)	VCC = Max,	VIN = 0V	, Outputs Open		2	4	mA	
ICC(0)	Supply Current (Both Drivers)	VCC = Max,	VIN = 3V	, Outputs Open		18	28	mA	
tPD(ON)	i i	$C_L = 15 \text{ pF}, V_L = -10V, R_L = 50\Omega,$			50		ns		
	(Output Turn ON)	$T_A = 25^{\circ}C$ , $V_{CC} = 5V$							
tPD(OFF	Propagation Delay to a Logical "1" (Output Turn OFF)	$C_L = 15 \text{ pF}, V_L = -10V, R_L = 50\Omega,$ $T_A = 25^{\circ}C, V_{CC} = 5V$		V, R <sub>L</sub> = 50Ω,		1.0		μs	

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

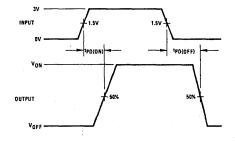
Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS1687 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS3687. All typicals are given for  $V_{CC} = 5V$  and  $T_{A} = 25^{\circ}$ C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

#### **AC Test Circuit and Switching Time Waveforms**



**Note 1:** The pulse generator has the following characteristics: PRR = 1 MHz, 50% duty cycle,  $Z_{OUT}\cong 50\Omega$ ,  $t_r=t_f\leq 10$  ns. **Note 2:**  $C_L$  includes probe and jig capacitance.



# Peripheral/Power Drivers

## DS55450/DS75450 Series Dual Peripheral Drivers

#### **General Description**

The DS55450/DS75450 series of dual peripheral drivers are a family of versatile devices designed for use in systems that use TTL logic. Typical applications include high speed logic buffers, power drivers, relay drivers. lamp drivers, MOS drivers, bus drivers and memory drivers.

The DS75450 is a general purpose device featuring two standard Series 54/74 TTL gates and two uncommitted. high current, high voltage NPN transistors. The device offers the system designer the flexibility of tailoring the circuit to the application.

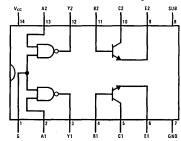
The DS55451/DS75451, DS55452/DS75452, DS55453/ DS75453 and DS55454/DS75454 are dual peripheral

AND, NAND, OR and NOR drivers, respectively, (positive logic) with the output of the logic gates internally connected to the bases of the NPN output transistors.

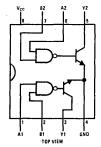
#### **Features**

- 300 mA output current capability
- High voltage outputs
- No output latch-up at 20V
- High speed switching
- Choice of logic function
- TTL compatible diode-clamped inputs
- Standard supply voltages
- Replaces TI "A" and "B" series

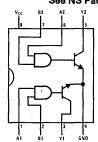
#### Connection Diagrams (Dual-In-Line and Metal Can Packages)



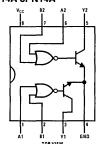
Order Number DS75450J or DS75450N See NS Package J14A or N14A



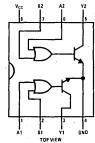
Order Number DS55451J-8. DS75451J-8 or DS75451N



Order Number DS55452J-8, DS75452J-8 or DS75452N

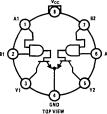


Order Number DS55453J-8. DS75453J-8 or DS75453N See NS Package J08A or N08A

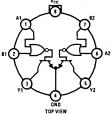


Order Number DS55454J-8. DS75454J-8 or DS75454N

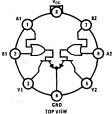
Order Number DS55451H or DS75451H



Order Number DS55452H or DS75452H



Order Number DS55453H or DS75453H See NS Package H08C



Order Number DS55454H or DS75454H

	· · · · · · · · · · · · · · · · · · ·
Absolute Maximum Ratin	IGS (Note 1)
Supply Voltage, (VCC) (Note 2)	7.0V
Input Voltage	5.5V
Inter-emitter Voltage (Note 3)	5.5V
V <sub>CC</sub> -to-Substrate Voltage	
DS75450	35V ·
Collector-to-Substrate Voltage	
DS75450	35V
Collector-Base Voltage	
DS75450	35V
Collector-Emitter Voltage (Note 4)	
DS75450	30V
Emitter-Base Voltage	
DS75450	5.0V
Output Voltage (Note 5)	
DS55451/DS75451, DS55452/DS75452,	30V
DS55453/DS75453, DS55454/DS75454	
Collector Current (Note 6)	
DS75450	300 mA
Output Current (Note 6)	
DS55451/DS75451, DS55452/DS75452,	300 mA
DS55453/DS75453, DS55454/DS75454	
DS75450 Maximum Power Dissipation* at 25	s°c
Cavity Package	1308 mW
Molded Package	1207 mW
DS75451/2/3/4 Maximum Power Dissipation	†at 25°C
Cavity Package	1090 mW
Molded Package	957 mW
TO-5 Package	760 mW
Storage Temperature Range	-65°C to +150°C
Lead Temperature (Soldering, 10 seconds)	260°C
•	

#### **Operating Conditions** (Note 7)

	MIN	MAX	UNITS
Supply Voltage,(V <sub>CC</sub> )			
DS5545X	4.5	5.5	V
DS7545X	4.75	5.25	V
Temperature, (TA)			
DS5545X	-55	+125	°C
DS7545X	0	+70	°C

<sup>\*</sup>Derate cavity package 8.7 mW/ $^{\circ}$ C above 25 $^{\circ}$ C; derate molded package 9.7 mW/ $^{\circ}$ C above 25 $^{\circ}$ C.

#### Electrical Characteristics DS75450 (Notes 8 and 9)

	PARAMETER		CONDITIONS		MIN	TYP	MAX	UNIT
TTL GATE	ES .							
VIH	High Level Input Voltage	(Figure 1)			2			V
VIL	Low Level Input Voltage	(Figure 2)					0.8	· v
V <sub>I</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>1</sub> = -12 mA, (Fig	ure 3)				-1.5	V
V <sub>OH</sub>	High Level Output Voltage	V <sub>CC</sub> = Min, V <sub>IL</sub> = 0.8V, I <sub>OH</sub> =	= -400μA, (Figu	re 2)	2.4	3.3		v
VoL	Low Level Output Voltage	V <sub>CC</sub> = Min, V <sub>IH</sub> = 2V, 1 <sub>OL</sub> =	16 mA (Figure 1	)	i	0.22	0.4	V
l <sub>1</sub>	Input Current at Maximum Input	V <sub>CC</sub> = Max, V <sub>I</sub> = 5.5V, (Figur	e 4)	Input A			1	m A
	Voltage			Input G .			2	m A
I <sub>IH</sub>	High Level Input Current	V <sub>CC</sub> = Max, V <sub>1</sub> = 2.4V, (Figur	e 4)	Input A			40	μA
				Input G	l		80	μА
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 0.4V, (Figur	e 3)	Input A			-1.6	m/
				Input G		T	-3.2	m
I <sub>os</sub>	Short Circuit Output Current	V <sub>CC</sub> = Max, (Figure 5), (Note	10)		-18		-55	m/
Іссн	Supply Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 0V, Outputs	High, (Figure 6	)		2	4	m/
IccL	Supply Current	V <sub>CC</sub> = Max, V <sub>i</sub> = 5V, Outputs Low, (Figure 6)				6	11	m/
OUTPUT 1	TRANSISTORS .							
V <sub>(BR)CBO</sub>	Collector-Base Breakdown Voltage	I <sub>C</sub> = 100μA, I <sub>E</sub> = 0			35			\ \
V <sub>(BR)CER</sub>	Collector-Emitter Breakdown Voltage	$I_{C} = 100\mu A, R_{BE} = 500\Omega$			30			,
V <sub>(BR)EBO</sub>	Emitter-Base Breakdown Voltage	I <sub>E</sub> = 100μA, I <sub>C</sub> = 0			5			1
h <sub>FE</sub>	Static Forward Current Transfer		T 105°0	I <sub>C</sub> = 100 mA	25			
	Ratio	V <sub>CE</sub> = 3V, (Note 11)	T <sub>A</sub> = +25°C	I <sub>C</sub> = 300 mA	30	l		
		VCE - SV, (NOTE 11)	T <sub>A</sub> = 0°C	I <sub>C</sub> = 100 mA	20			
			14-00	I <sub>C</sub> = 300 mA	25			
V <sub>BE</sub>	Base-Emitter Voltage	(Note 11)		I <sub>B</sub> = 10 mA, I <sub>C</sub> = 100 mA		0.85	1	
		(1.010 1.1)		$I_B = 30 \text{ mA}, I_C = 300 \text{ mA}$		1.05	1.2	
V <sub>CE(SAT)</sub>	Collector-Emitter Saturation	(Note 11)		I <sub>B</sub> = 10 mA, I <sub>C</sub> = 100 mA		0.25	0.4	
	Voltage			$I_B = 30 \text{ mA}, I_C = 300 \text{ mA}$	1	0.5	0.7	· '

<sup>†</sup> Derate cavity package 7.3 mW/°C above 25°C; derate molded package 7.7 mW/°C above 25°C; derate TO-5 package 5.1 mW/°C above 25°C.

#### **Electrical Characteristics** (Continued)

DS55451/DS75451, DS55452/DS75452, DS55453/DS75453, DS55454/DS75454 (Notes 8 and 9)

	PARAMETER		CONDITIONS			MIN	TYP	MAX	UNITS
ViH	High-Level Input Voltage	:				2			V
VIL	Low-Level Input Voltage	(Figure 7)	(Figure 7)					0.8	V
V <sub>I</sub>	Input Clamp Voltage	V <sub>cc</sub> = Min,	I <sub>I</sub> = -12 mA					-1.5	V
VoL	Low-Level Output Voltage				DS55451, DS55453		0.25	0.5	V
			I <sub>OL</sub> = 100 mA	DS75451, DS75453		0.25	0.4	V	
	V <sub>IL</sub> = 0.8V		DS55451, DS55453		0.5	0.8	V		
	•	V <sub>CC</sub> = Min,		I <sub>OL</sub> = 300 mA	DS75451, DS75453		0.5	0.7	V
		(Figure 7)		I <sub>OL</sub> = 100 mA	DS55452, DS55454		0.25	0.5	V
			V <sub>IH</sub> = 2V	101 - 100 1114	DS75452, DS75454		0.25	0.4	V
	, vih		1 TH 2 T	I <sub>OL</sub> = 300 mA	DS55452, DS55454		0.5	0.8	V
			10[ - 300 1117	DS75452, DS75454	<u> </u>	0.5	0.7	V	
IoH	High-Level Output Current	High-Level Output Current	$V_{CC} = Min$ , $V_{OH} = 30V$	DS55451, DS55453			300	μΑ	
		V <sub>CC</sub> = Min,		VIH - ZV	DS75451, DS75453			100	μΑ
		(Figure 7)	VOH - 30V	V <sub>IL</sub> = 0.8V	DS55452, DS55454			300	μΑ
				VIL - 0.8V	DS75452, DS75454			100	μА
- 4	Input Current at Maximum Input Voltage	V <sub>CC</sub> = Max,	V <sub>1</sub> = 5.5V, (F	igure 9)				1	mA
I <sub>IH</sub>	High-Level Input Current	V <sub>CC</sub> = Max,	V <sub>1</sub> = 2.4V, (F	igure 9)				40	μΑ
IIL	Low-Level Input Current	V <sub>CC.</sub> = Max,	V <sub>1</sub> = 0.4V, (F	igure 8)			-1	-1.6	mA
I <sub>cch</sub>	Supply Current, Outputs High		V, = 5V		DS55451/DS75451		7	11	mA
		V <sub>CC</sub> = Max,	V <sub>1</sub> = 0V	-	DS55452/DS75452		11	14	mA
		(Figure 10)	V <sub>1</sub> = 5V		DS55453/DS75453		8	11	mA
			V <sub>1</sub> = 0V		DS55454/DS75454		13	17	mA
I <sub>CCL</sub>	Supply Current, Outputs Low		V <sub>1</sub> = 0V		DS55451/DS75451		52	65	mA
		V <sub>CC</sub> = Max,	V <sub>1</sub> = 5V		DS55452/DS75452		56	71	mA
		(Figure 10)	V <sub>1</sub> = 0V		DS55453/DS75453		54	68	mA
			V, = 5V		DS55454/DS75454		61	79	mA

#### **Switching Characteristics**

DS75450 ( $V_{CC} = 5V, T_A = 25^{\circ}C$ )

	PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>PLH</sub>	Propagation Delay Time,		R <sub>L</sub> = 400Ω, TTL Gates, (Figure 12)		12	22	ns
	Low-To-High Level Output	C <sub>L</sub> = 15 pF	$R_L = 50\Omega$ , $I_C \approx 200$ mA, Gates and Transistors Combined, (Figure 14)		20	30	ns
t <sub>PHL</sub>	Propagation Delay Time,		$R_L = 400\Omega$ , TTL Gates, (Figure 12)		8	15	ns
	High-To-Low Level Output	C <sub>L</sub> = 15 pF	$R_L = 50\Omega$ , $I_C \approx 200$ mA, Gates and Transistors Combined, (Figure 14)		20	30	ns
t <sub>TLH</sub>	Transition Time, Low-To-High Level Output	C <sub>L</sub> = 15 pF, R <sub>L</sub> = (Figure 14)	$C_L$ = 15 pF, $~R_L$ = 50 $\Omega,~I_C\approx 200$ mA, Gates and Transistors Combined, (Figure 14)		7	12	ns
t <sub>THL</sub>	Transition Time, High-To-Low Level Output	$\rm C_L$ = 15 pF, $\rmR_L$ = 50 $\Omega,\rm I_C\approx 200$ mA, Gates and Transistors Combined, (Figure 14)			9	15	ns
V <sub>OH</sub>	High-Level Output Voltage After Switching	$V_S = 20V$ , $I_C \approx 3$	$V_{S}$ = 20V, $I_{C} \approx 300$ mA, $R_{BE}$ = 500 $\Omega$ , (Figure 15)				mV
t <sub>D</sub>	Delay Time		$I_{1} = 20 \text{ mA}, I_{B} = -40 \text{ mA}, V_{BE(OFF)} = -1V,$ $I_{2} = 50\Omega, (Figure 13), (Note 12)$		8	15	ns
t <sub>R</sub>	Rise Time		$I_{1} = 20 \text{ mA}, I_{B} = -40 \text{ mA}, V_{BE(OFF)} = -1V,$ $I_{2} = 50\Omega, (Figure 13), (Note 12)$		12	20	ns
t <sub>S</sub>	Storage Time		$I_C$ = 200 mA, $I_{B(1)}$ = 20 mA, $I_B$ = -40 mA, $V_{BE(OFF)}$ = -1V, $C_L$ = 15 pF, $R_L$ = 50 $\Omega$ , (Figure 13), (Note 12)		7	15	ns
t <sub>F</sub>	Fall Time	$I_C = 200 \text{ mA}, \ I_{B(1)} = 20 \text{ mA}, \ I_B = -40 \text{ mA}, \ V_{BE(OFF)} = -1V,$ $C_L = 15 \text{ pF}, \ R_L = 50\Omega; \ \textit{(Figure 13), (Note 12)}$			6	15	ns

#### Switching Characteristics (Continued)

DS55451/DS75451, DS55452/DS75452, DS55453/DS75453, DS55454/DS75454 ( $V_{CC} = 5V$ ,  $T_A = 25^{\circ}C$ )

	PARAMETER	CONDITIO	CONDITIONS			MAX	UNITS
t <sub>PLH</sub>	Propagation Delay Time, Low-To-High		DS55451/DS75451		18	25	ns
	Level Output	$C_L = 15  pF, R_L = 50\Omega,$	DS55452/DS75452		26	35	ns
		I <sub>O</sub> ≈ 200 mA, (Figure 14)	DS55453/DS75453		18	25	ns
	•		DS55454/DS75454		27	35	ns
t <sub>PHL</sub>	Propagation Delay Time, High-To-Low		DS55451/DS75451		18	25	ns
	Level Output	$C_{L} = 15  pF, R_{L} = 50 \Omega,$	DS55452/DS75452		24	35	ns
		I <sub>O</sub> ≈ 200 mA, (Figure 14)	DS55453/DS75453		16	25	ns
			DS55454/DS75454		24	35	ns
t <sub>TLH</sub>	Transition Time, Low-To-High Level Output	$C_L$ = 15 pF, $R_L$ = 50 $\Omega$ , $I_O$ $\approx$ 200 mA, (Figure 14)			5	8	ns
t <sub>THL</sub>	Transition Time, High-To-Low Level Output	$C_L$ = 15 pF, $R_L$ = 50 $\Omega$ , $I_O$ $\approx$ 200 mA, (Figure 14)			. 7	12	ns
V <sub>OH</sub>	High-Level Output Voltage After Switching	$V_S$ = 20V, $I_O \approx 300$ mA, (Figure 15)		V <sub>S</sub> -6.5	i		mV

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Voltage values are with respect to network ground terminal unless otherwise specified.

Note 3: The voltage between two emitters of a multiple-emitter transistor,

Note 4: Value applies when the base-emitter resistance (RBE) is equal to or less than  $500\Omega$ .

Note 5: The maximum voltage which should be applied to any output when it is in the "OFF" state.

Note 6: Both halves of these dual circuits may conduct rated current simultaneously; however, power dissipation averaged over a short time, interval must fall within the continuous dissipation rating.

Note 7: For the DS75450 only, the substrate (pin 8) must always be at the most-negative device voltage for proper operation.

Note 8: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS55450 series and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS75450 series. All typicals are given for  $V_{CC}$  = +5V and  $T_{A}$  =  $25^{\circ}$ C.

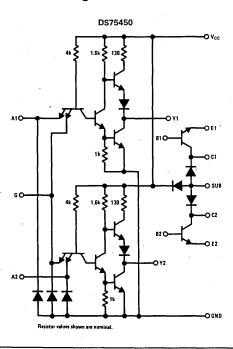
Note 9: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

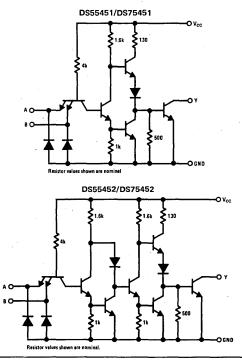
Note 10: Only one output at a time should be shorted.

Note 11: These parameters must be measured using pulse techniques.  $t_W = 300\mu s$ , duty cycle < 2%.

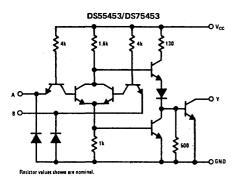
Note 12: Applies to output transistors only.

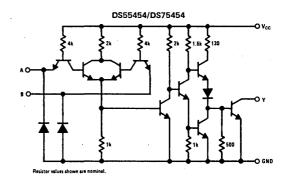
#### **Schematic Diagrams**





#### Schematic Diagrams (Continued)





Truth Tables (H = high level, L = low level)

DS55451/DS75451

Α	В	, Y
L	L	L (ON State)
. L	Н	L (ON State)
Н	L	L (ON State)
Н	Н	H (OFF State)

DS55452/DS75452

Α	В	Υ
L	L	H (OFF State)
L	Н	H (OFF State)
Н	L	H (OFF State)
Н	Н	L (ON State)

DS55453/DS75453

Α	В	Υ
L	L	L (ON State)
L	Н	H (OFF State)
н	L	H (OFF State)
. н	н	H (OFF State)

#### DS55454/DS75454

Α	В	Υ
L	L	H (OFF State)
L	Н	L (ON State)
Н	L.	L (ON State)
* H	Н	L (ON State)

#### **DC Test Circuits**

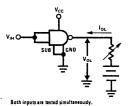


FIGURE 1. VIH, VOL

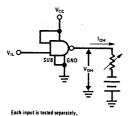


FIGURE 2. VIL. VOH

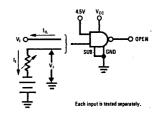


FIGURE 3. VI, IIL

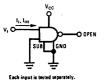
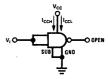


FIGURE 4. IJ, IIH



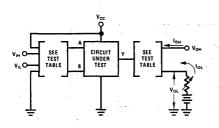
FIGURE 5. IOS



Both gates are tested simultaneously

FIGURE 6. ICCH, ICCL

#### DC Test Circuits (Continued)



	INPUT	OTHER	ООТРИТ			
CIRCUIT	UNDER	INPUT	APPLY	MEASURE		
DS54451	V <sub>IH</sub> V <sub>IL</sub>	V <sub>IH</sub> V <sub>CC</sub>	V <sub>OH</sub>	I <sub>OH</sub> V <sub>OL</sub>		
DS54452	V <sub>IH</sub> V <sub>IL</sub>	V <sub>IH</sub> V <sub>CC</sub>	I <sub>ÖL</sub> V <sub>OH</sub>	V <sub>OL</sub> I <sub>OH</sub>		
DS54453	V <sub>IH</sub> V <sub>IL</sub>	Gnd V <sub>IL</sub>	V <sub>OH</sub>	I <sub>он</sub> V <sub>ol</sub>		
DS54454	V <sub>IH</sub> V <sub>IL</sub>	Gnd V <sub>IL</sub>	I <sub>OL</sub>	V <sub>OL</sub> I <sub>OH</sub>		

FIGURE 7. VIH, VIL, IOH, VOL

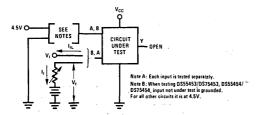


FIGURE 8. VI, IIL

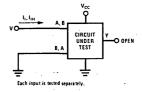


FIGURE 9. I<sub>1</sub>, I<sub>1H</sub>

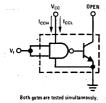


FIGURE 10. ICCH, ICCL for AND, NAND Circuits

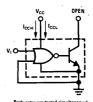
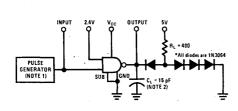
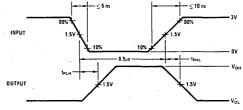


FIGURE 11. I<sub>CCH</sub>, I<sub>CCL</sub> for OR, NOR Circuits

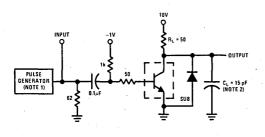
#### **AC Test Circuits and Switching Time Waveforms**

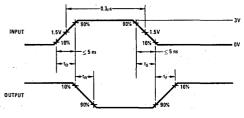




Note 1: The pulse generator has the following characteristics: PRR = 1 MHz,  $Z_{OUT}\approx 50\Omega$ . Note 2:  $C_L$  include probe and jig capacitance.

FIGURE 12. Propagation Delay Times, Each Gate (DS75450 Only)





Note 1: The pulse generator has the following characteristics: duty cycle  $\leq$  1%,  $Z_{OUT} \approx 50\Omega$ .

Note 2: Ct includes probe and jig capacitance

FIGURE 13. Switching Times, Each Transistor (DS75450 Only)

#### AC Test Circuits and Switching Time Waveforms (Continued)

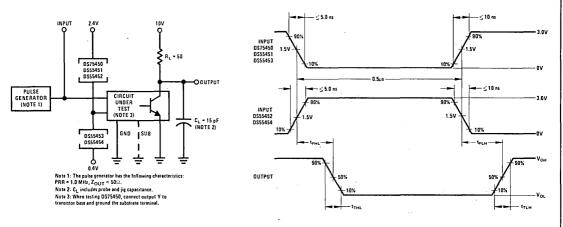


FIGURE 14. Switching Times of Complete Drivers

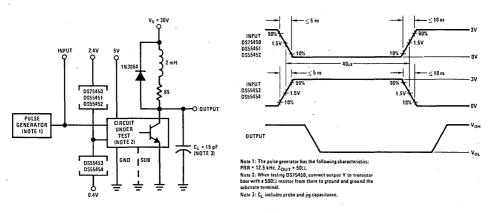


FIGURE 15. Latch-Up Test of Complete Drivers

#### **Typical Performance Characteristics**

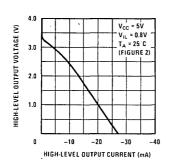


FIGURE 16. DS75450 TTL Gate High-Level Output Voltage vs High-Level Output Current

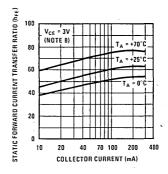


FIGURE 17. DS75450 Transistor Static Forward Current Transfer Ratio vs Collector Current

#### Typical Performance Characteristics (Continued)

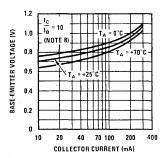


FIGURE 18. DS75450 Transistor Base-Emitter Voltage vs Collector Current

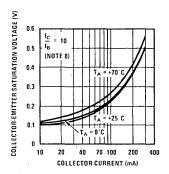


FIGURE 19. Transistor Collector-Emitter Saturation Voltage vs Collector Current

#### **Typical Applications**

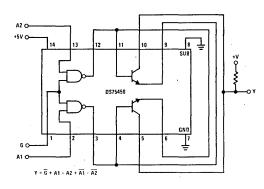


FIGURE 20, Gated Comparator

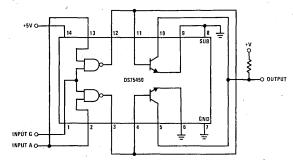


FIGURE 21, 500 mA Sink

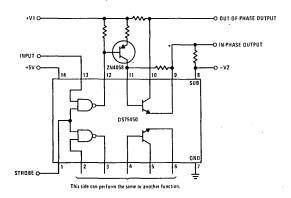


FIGURE 22. Floating Switch

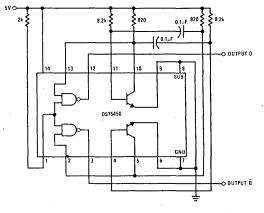


FIGURE 23. Square-Wave Generator

#### Typical Applications (Continued)

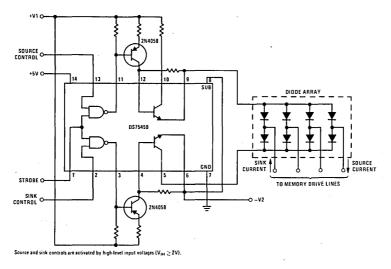


FIGURE 24. Core Memory Driver

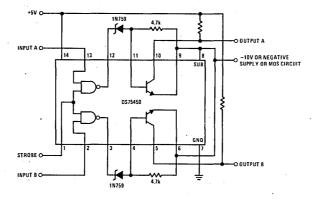


FIGURE 25. Dual TTL-to-MOS Driver

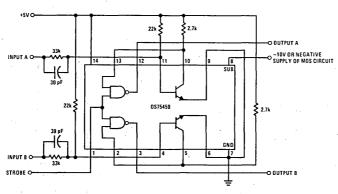


FIGURE 26. Dual MOS-to-TTL Driver

#### Typical Applications (Continued)

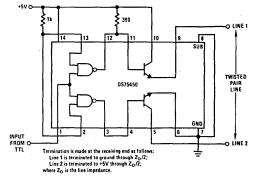


FIGURE 27. Balanced Line Driver

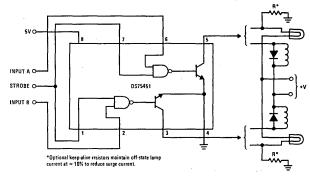


FIGURE 28. Dual Lamp or Relay Driver

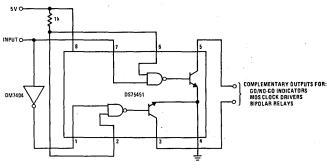


FIGURE 29. Complementary Driver

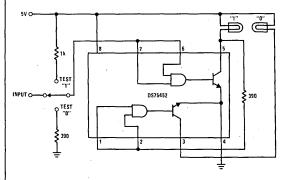


FIGURE 30. TTL or DTL Positive Logic-Level Detector

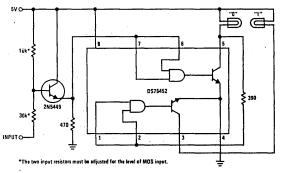


FIGURE 31. MOS Negative Logic-Level Detector

# Typical Applications (Continued)

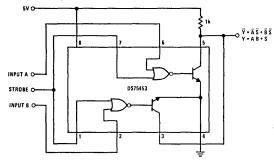


FIGURE 32. Logic Signal Comparator

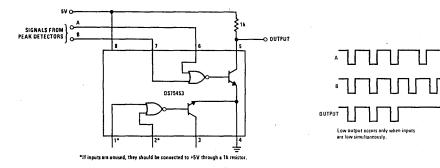


FIGURE 33. In-Phase Detector

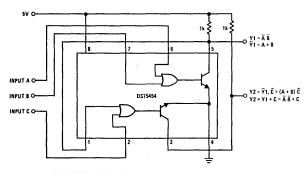


FIGURE 34. Multifunction Logic-Signal Comparator

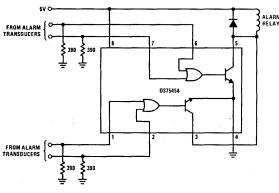


FIGURE 35. Alarm Detector

# **Peripheral/Power Drivers**

# DS55461/2/3/4, DS75461/2/3/4 Series Dual Peripheral Drivers

#### General Description

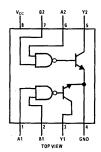
The DS55461/2/3/4 series of dual peripheral drivers are functionally interchangeable with DS55451/2/3/4 series peripheral drivers, but are designed for use in systems that require higher breakdown voltages at the expense of slightly slower switching speeds. Typical applications include power drivers, logic buffers, lamp drivers, relay drivers, MOS drivers, line drivers and memory drivers:

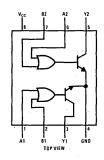
The DS55461/DS75461, DS55462/DS75462, DS55463/DS75463 and DS55464/DS75464 are dual peripheral AND, NAND, OR and NOR drivers, respectively, (positive logic) with the output of the logic gates internally connected to the bases of the NPN output transistors.

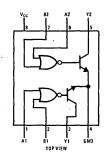
#### **Features**

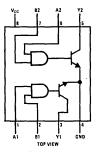
- 300 mA output current capability
- High voltage outputs
- 'No output latch-up at 30V
- Medium speed switching
- Circuit flexibility for varied applications and choice of logic function
- TTL compatible diode-clamped inputs
- Standard supply voltages

#### Connection Diagrams (Dual-In-Line and Metal Can Packages)









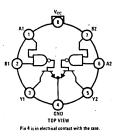
Order Number DS55461J-8, DS75461J-8 or DS75461N

Order Number DS55462J-8, DS75462J-8 or DS75462N

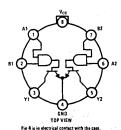
Order Number DS55463J-8, DS75463J-8 or DS75463N

Order Number DS55464J-8, DS75464J-8 or DS75464N

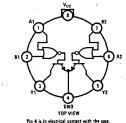
#### See NS Package J08A or N08A



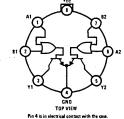
Order Number DS55461H or DS75461H



Order Number DS55462H or DS75462H



Order Number DS55463H or DS75463H



Order Number DS55464H or DS75464H

See NS Package H08C

Absolute Maximum Ratin	Operating Conditions				
			MIN	MAX	UNITS
Supply Voltage (Note 2)	7V	Supply Voltage (VCC)	4.5	5.5	V
Input Voltage	5.5V	D\$5546X D\$7546X	4.5 4.75	5.25	V
Inter-emitter Voltage (Note 3) Output Voltage (Note 4) DS55461/DS75461, DS55462/DS75462, DS55463/DS75463. DS55464/DS75464	5.5V 35V	Temperature (T <sub>A</sub> ) DS5546X	-55 0	+125 +70	°c °c
Output Current (Note 5) DS55461/DS75461, DS55462/DS75462, DS55463/DS75463, DS55464/DS75464 Maximum Power Dissipation* at 25°C	300 mA	DS7546X	U	+70	C
Cavity Package	1090 mW				
Molded Package	957 mW				
TO-5 Package	760 mW				
Storage Temperature Range Lead Temperature (Soldering, 10 seconds)	–65°C to +150°C 260°C				
*Derate cavity package 7.3 mW/°C above 25 package 7.7 mW/°C above 25 °C; derate TO-5 °C above 25 °C.	C; derate molded package 5.1 mW/				

# **Electrical Characteristics**

DS55461/DS75461, DS55462/DS75462, DS55463/DS75463, DS55464/DS75464 (Notes 6 and 7)

PARAMETER		CONDITIONS			MIN	TYP	MAX	UNITS
V <sub>IH</sub>	High Level Input Voltage	(Figure 1)			2			٧
V <sub>IL</sub>	Low Level Input Voltage	(Figure 1)					0.8	<b>V</b>
v,	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>I</sub> = -12 n	nA			-1.2	-1.5	V
VoL	Low Level Output Voltage		· · · · · · · · · · · · · · · · · · ·	I <sub>OL</sub> = 100 mA		0.15	0.5	V
OL.			DS55461, V <sub>IL</sub> = 0.8V	I <sub>OL</sub> = 300 mA		0.36	0.8	V
			2055402 14 204	I <sub>OL</sub> = 100 mA		0.16	0.5	V
			DS55462, V <sub>IH</sub> =2V	1 <sub>OL</sub> = 300 mA		0.35	0.8	>
			DS55463, V <sub>II</sub> =0.8V	I <sub>OL</sub> = 100 mA		0.18	0.5	٧
			D333403, V <sub>IL</sub> =0.8V	I <sub>OL</sub> = 300 mA		0.39	0.8	V
			DS55464, V <sub>IH</sub> =2V	I <sub>OL</sub> ≈ 100 mA		0,17	0.5	V
	•	V <sub>CC</sub> = Min,(Figure 1)	2000 (O.1, VIA 2.V	I <sub>OL</sub> = 300 mA		0.38	8.0	V
	•		DS75461, V <sub>IL</sub> =0.8V	I <sub>OL</sub> = 100 mA		0.15	0.4	V
				I <sub>OL</sub> = 300 mA		0.36	0.7	V
			DS75462, V <sub>IH</sub> =2V	I <sub>OL</sub> = 100 mA		0.16	0.4	V ′
			<del></del>	I <sub>OL</sub> = 300 mA		0.35 0.18	0.7	V
			DS75463, V <sub>IL</sub> =0.8V	I <sub>OL</sub> = 100 mA	<del> </del>	0.18	0.4	· ·
		DS754	<del></del>	I <sub>OL</sub> = 100 mA	<del> </del>	0.33	0.4	v
	DS75464, V <sub>IH</sub> =2V		I <sub>OL</sub> = 300 mA	<del> </del>	0.38	0.7	V	
 І <sub>он</sub>	High Level Output Current			DS55461,				
ОН	riigii Zarai Gatpat Gariant			DS55463			300	μΑ
			V <sub>IH</sub> = 2V	DS75461,			400	
		V <sub>CC</sub> = Min, V <sub>OH</sub> =		DS75463			100	μΑ
		35V, (Figure 1)		DS55462,			300	μΑ
			V <sub>IL</sub> = 0.8V	DS55464			300	μη.
			. 0.51	DS75462,			100	μА
				DS75464				
l <sub>i</sub>	Input Current at Maximum Input Voltage	V <sub>CC</sub> = Max, V <sub>I</sub> = 5.5\	I, (Figure 3)			į į	1	mA
Ін	High Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 2.4\	I, (Figure 3)	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,			40	μΑ
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 0.4\	J, (Figure 2)			-1	-1.6	mA
ССН	Supply Current		,	DS55461/				
	•			DS75461,		8	١.,	^
			V, = 5V	DS55463/		8	11	· mA
		V <sub>CC</sub> = Max, Outputs		DS75463	<u> </u>			
		V <sub>CC</sub> = Max, Outputs High, (Figures 4 and 5)		DS55462/		13	17	mA
			V <sub>1</sub> = 0V	DS75462				
			l <sup>*</sup>	DS55464/	1	14	19	mA

#### **Electrical Characteristics** (Continued)

DS55461/DS75461, DS55462/DS75462, DS55463/DS75463, DS55464/DS75464 (Notes 6 and 7)

	PARAMETER	CONDITIONS			MIN	TYP	MAX	UNITS
Iccr	Supply Current			DS55461/ DS75461		61	76	mA
		V = 8500 O(10000	V <sub>1</sub> = 0V	DS55463/ DS75463		63	76	mA
		V <sub>CC</sub> = Max, Outputs Low, (Figures 4 and 5)	1	DS55462/ DS75462		65	76	mA
			V <sub>1</sub> = 5V	DS55464/ DS75464		72	85	mA

#### **Switching Characteristics**

DS55461/DS75461, DS55462/DS75462, DS55463/DS75463, DS55464/DS75464  $V_{CC}$  = 5V,  $T_A$  = 25°C

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
t <sub>PLH</sub>	Propagation Delay Time, Low-To-High Level Output	$I_{O} \approx 200$ mA, $C_{L}$ = 15 pF, $R_{L}$ = $50\Omega$ ,	DS55461/ DS75461, DS55463/ DS75463		45	. 55	ns
		(Figure 6)	DS55462/ DS75462, DS55464/ DS75464		50	65	ns
t <sub>PHL</sub>	Propagation Delay Time, High-To-Low Level Output	$I_{\rm O} \approx$ 200 mA, $C_{\rm L}$ = 15 pF, $R_{\rm L}$ = 50 $\Omega$ ,	DS55461/ DS75461, DS55463/ DS75463		30	40	ns
		(Figure 6)	DS55462/ DS75462, DS55464/ DS75464		40	50	ns
t <sub>TLH</sub>	Transition Time, Low-To-		DS55461/ DS75461		8	20	ns
		$I_{O} \approx 200 \text{ mA}, C_{1} = 15 \text{ pF}, R_{L} = 50\Omega,$	DS55462/ DS75462		12	25	ns
		(Figure 6)	DS55463/ DS75463		8	25	ns
			DS55464/ DS75464		12	20	ns
t <sub>THL</sub>	Transition Time, High-To- Low Level Output		DS55461/ DS75461		10	20	ns
		$I_{O} \approx 200 \text{ mA}, C_{L} = 15 \text{ pF}, R_{L} = 50\Omega,$ (Figure 6)	DS55462/ DS75462, DS55464/ DS75464		15	20	ns
			DS55463/ DS75463		10	25	ns
V <sub>OH</sub>	High-Level Output Voltage After Switching	$V_S = 30V$ , $I_O \approx 300$ mA, (Figure 7)		V <sub>S</sub> -10			mV

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Voltage values are with respect to network ground terminal unless otherwise specified.

Note 3: This is the voltage between two emitters of a multiple-emitter transistor.

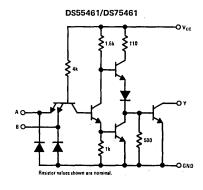
Note 4: This is the maximum voltage which should be applied to any output when it is in the "OFF" state.

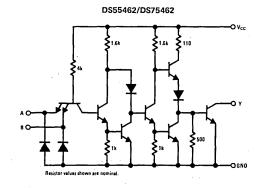
Note 5: Both halves of these dual circuits may conduct rated current simultaneously; however, power dissipation averaged over a short time interval must fall within the continuous dissipation rating.

Note 6: Unless otherwise specified min/max limits apply across the  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  temperature range for the DS55XXX series and across the  $0^{\circ}\text{C}$  to  $+70^{\circ}\text{C}$  range for the DS75XXX series. All typicals are given for  $V_{CC} = +5V$  and  $T_{A} = 25^{\circ}\text{C}$ .

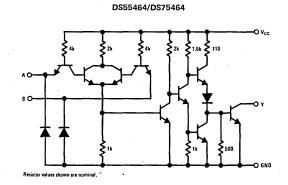
Note 7: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

# **Schematic Diagrams**





# 



#### Truth Tables (H = high level, L = low level)

DS55461/DS75461

Α	В	Y
L	L	L (ON State)
L	н	L (ON State)
Н	L	L (ON State)
Н	н	H (OFF State)

DS5	5462	/ns7	15462

Α	В	Y
L	L	H (OFF State)
L	Н	H (OFF State)
H	L	H (OFF State)
н	н	L (ON State)

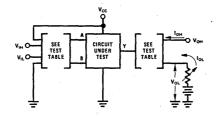
DS55463/DS75463

A	В	Y
L	٦	L (ON State)
L	н	H (OFF State)
Н	L	H (OFF State)
н	н	H (OFF State)

DS55464/DS75464

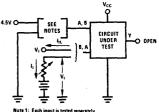
Α	В	Y
L	L	H (OFF State)
L	н	L (ON State)
н	L	L (ON State)
н	н	L (ON State)

#### **DC Test Circuits**



CIRCUIT	INPUT UNDER	OTHER	ОИТРИТ	
CIRCUIT	TEST	INPUT	APPLY	MEASURE
DS55461	V <sub>IH</sub>	V <sub>IH</sub>	V <sub>OH</sub>	I <sub>он</sub>
	V <sub>IL</sub>	V <sub>CC</sub>	I <sub>OL</sub>	V <sub>oL</sub>
DS55462	V <sub>IH</sub>	V <sub>IH</sub>	I <sub>OL</sub>	V <sub>OL</sub>
	V <sub>IL</sub>	V <sub>CC</sub>	V <sub>OH</sub>	Іон
DS55463	V <sub>IH</sub>	Gnd	V <sub>OH</sub>	I <sub>он</sub>
	V <sub>IL</sub>	V <sub>IL</sub>	I <sub>OL</sub>	V <sub>oL</sub>
DS55464	V <sub>IH</sub>	Gnd	I <sub>OL</sub>	V <sub>OL</sub>
	V <sub>IL</sub>	V <sub>IL</sub>	V <sub>OH</sub>	I <sub>OH</sub>

FIGURE 1. VIH, VIL, IOH, VOL



Note 1: Each input is tested separately.

Note 2: When testing DS55463/DS75463 and DS75464, input not under test is grounded.

For all other circuits it is at 4.5V.

FIGURE 2. VI, IIL

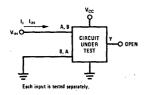
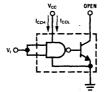


FIGURE 3. II, IIH



Both gates are tested simultaneously.





Both cates are tested simultaneously

FIGURE 5. I<sub>CCH</sub>, I<sub>CCL</sub> for OR, NOR Circuits

#### **Switching Characteristics**

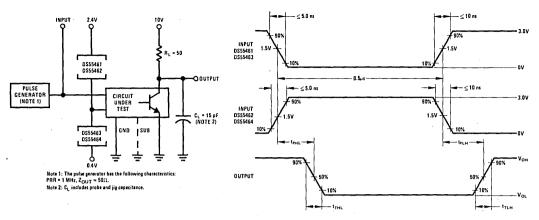


FIGURE 6. Switching Times of Complete Drivers

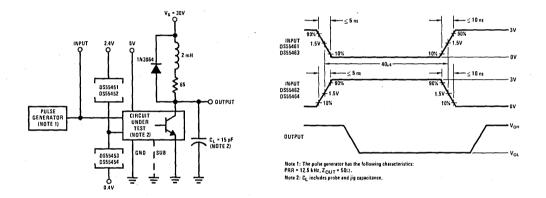


FIGURE 7. Latch-Up Test of Complete Drivers

# Safe Operating Areas for Peripheral Drivers

National Semiconductor Application Note 213 Bill Fowler October 1978



Peripheral Drivers is a broad definition given to Interface Power devices. The devices generally have open-collector output transistors that can switch hundreds of milliamps at high voltage, and are driven by standard Digital Logic gates. They serve many applications such as: Relay Drivers, Printer Hammer Drivers, Lamp Drivers, Bus Drivers, Core Memory Drivers, Voltage Level Transistors, and etc. Most IC devices have a specified maximum load such as one TTL gate can drive ten other TTL gates. Peripheral drivers have many varied load situations depending on the application, and requires the design engineer to interpret the limitations of the device vs its application. The major considerations are Peak Current, Breakdown Voltage, and Power Dissipation.

# OUTPUT CURRENT AND VOLTAGE CHARACTERISTICS

Figure 1 shows the circuit of a typical peripheral driver, the DS75451. The circuit is equivalent to a TTL Gate driving a 300 mA output transistor. Figure 2 shows the characteristics of the output transistor when it is ON and when it is OFF. The output transistor is capable of sinking more than one amp of current when it is ON, and is specified at a  $V_{OL} = 0.7V$  at 300 mA. The output transistor is also specified to operate with voltages up to 30V without breaking down, but there is more to that as shown by the breakdown voltages labeled BVCES, BVCER, and LVCEO.

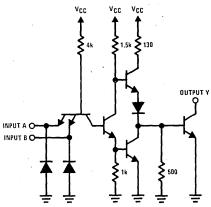


FIGURE 1. Typical Peripheral Driver DS75451

BVCES corresponds to the breakdown voltage when the output transistor is held off by the lower output transistor of the TTL gate, as would happen if the power supply (VCC) was 5V. BVCER corresponds to the breakdown voltage when the output transistor is held off by the 500 resistor, as would happen if the power supply (VCC) was off (0V). LVCEO corresponds to the breakdown voltage of the output transistor if it could be measured with the base open. LVCEO can be measured by exceeding the breakdown voltage BVCES and measuring the voltage at output currents

of 1 to 10 mA on a transistor curve tracer (LVCEO is sometimes measured in an Inductive Latch-Up Test). Observe that all breakdown voltages converge on LVCEO at high currents, and that destructive secondary breakdown voltage occurred (shown as dotted line) at high currents and high voltage corresponding to exceeding the power dissipation of the device. The characteristics of secondary breakdown voltage vary with the length of time the condition exists, device temperature, voltage, and current.

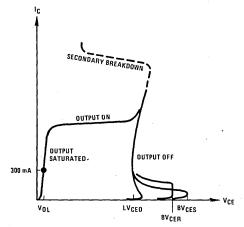


FIGURE 2. Output Characteristics ON and OFF

# OUTPUT TRANSFER CHARACTERISTICS VS INDUCTIVE AND CAPACITIVE LOADS

Figure 3 shows the switching transfer characteristics superimposed on the DC characteristics of the output transistor for an inductive load. Figure 4 shows the switching transfer characteristics for a capacitor load. In both cases in these examples, the load voltage (VB) exceeds LVCEO. When the output transistor turns on with an inductive load the initial current through the load is 0 mA, and the transfer curve switches across to the left (VOL) and slowly charges the inductor. When the output transistor turns off with an inductive load, the initial current is IOL, which is sustained by the inductor and the transistor curve switches across to the right (VB) through a high current and high voltage area which exceeds LVCEO and instead of turning off (shown as dotted line) the device goes into secondary breakdown. It is generally not a good practice to let the output transistor's voltage exceed LVCEO with an inductive load.

In a similar case with a capacitive load shown in Figure 4, the switching transfer characteristics rotate counter clockwise through the DC characteristics, unlike the inductive load which rotated clockwise. Even though the switching transfer curve exceeds LVCEO, it didn't

go into secondary breakdown. Therefore, it is an acceptable practice to let the output transistor voltage exceed LVCEO, but not exceed BVCER with a capacitive load.

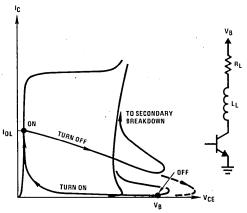


FIGURE 3. Inductive Load Transfer Characteristics

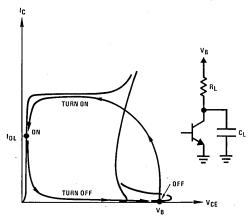


FIGURE 4. Capacitive Load Transfer Characteristics

Figure 5 shows an acceptable application with an inductive load. The load voltage (VB) is less than LVCEO, and the inductive voltage spike caused by the initial inductive current is quenched by a diode connected to VB.

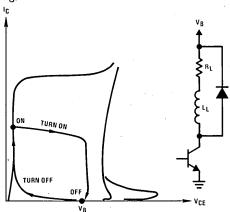


FIGURE 5. Inductive Load Transfer Characteristics Clamped by Diode

Figure 6 shows the switching transfer characteristics of a capacitive load which leads to secondary breakdown. This condition occurs due to high sustained currents, not breakdown voltage. In this example, the large capacitor prevented the output transistor from switching fast enough through the high current and high voltage region; in turn the power dissipation of the device was exceeded and the output transistor went into secondary breakdown.

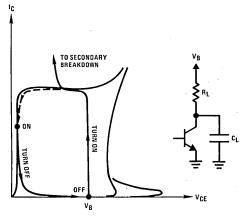


FIGURE 6. Capacitive Load Transfer Characteristics

Figure 7 shows another method of quenching the inductive voltage spike caused by the initial inductive current. This method dampens the switching response by the addition of RD and CD. The values of RD and CD are chosen to critically dampen the values of RL and LL; this will limit the output voltage to 2 x VB.

$$\frac{L_{L}}{(R_{L} + R_{D})} \times \sqrt{\frac{1}{L_{L}C_{D}}} \leq 0.5$$

FIGURE 7. Inductive Load Dampened by Capacitor

Figure 8 shows a method of reducing high sustaining currents in a capacitive load. RD in series with the capacitor (CL) will limit the switching transistor without effecting final amplitude of the output voltage, since the IR drop across RD will be zero after the capacitor is charged.

As an additional warning, beware of parasitic reactance. If the driver's load is located some distance from the driver (as an example: on the inclosure panel or through a connecting cable) there will be additional inductive and capacitance which may cause ringing on the driver

output which will exceed LVCEO or transient current that exceeds the sustaining current of the driver. A 300 mA current through a small inductor can cause a good size transient voltage, as compared with a 20 mA transient current observed with TTL gates. For no other reason than to reduce the noise associated with these transients, it is good practice to dampen the driver's output.

In conclusion, transient voltage associated with inductive loads can damage the peripheral driver, and transient currents associated with capacitive loads can also damage the driver. In some instances the device may not exhibit failure with the first switching cycle, but its conditions from ON to OFF will worsen after many cycles. In some cases the device will recover after the power has been turned off, but its long term reliability may have been degraded.

#### POWER DISSIPATION

Power Dissipation is limited by the IC Package Thermal Reactance and the external thermal reactance of the environment (PC board, heat sink, circulating air, etc.). Also, the power dissipation is limited by the maximum allowable junction temperature of the device. There are two contributions to the power: the internal

bias currents and voltage of the device, and the power on the output of the device due to the Driver Load.

#### POWER LIMITATIONS OF PACKAGE

Figure 9 shows the equivalent circuit of a typical power device in its application. Power is shown equivalent to electrical current, thermal resistance is shown equivalent to electrical resistance, the electrical reactance C and L are equivalent to the capacity to store heat, and the propagation delay through the medium. There are two mediums of heat transfer: conduction through mass and radiant convection. Convection is insignificant compared with conduction and isn't shown in the thermal resistance circuits. From the point power is generated (device junction) there are three possible paths to the ultimate heat sink: 1. through the device leads; 2. through the device surface by mechanical connection; and 3. through the device surface to ambient air. In all cases, the thermal paths are like delay lines and have a corresponding propagation delay. The thermal resistance is proportional to the length divided by the cross sectional area of the material. The Thermal Inductance is proportional to the length of the material (copper, molding compound, etc.) and inversely proportional to the cross sectional area. The thermal capacity is proportional to the volume of the material.

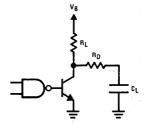


FIGURE 8. Capacitive Load with Current Limiting Resistor

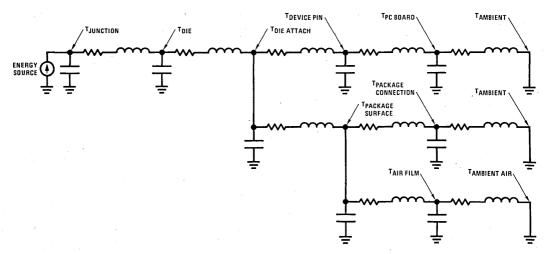


FIGURE 9. Thermal Reactance from Junction to Ambient

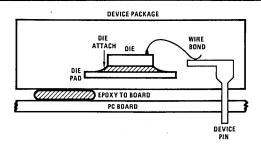


FIGURE 10. Components of Thermal Reactance for a Typical IC Package

National Semiconductor specifies the thermal resistance from device junction through the device leads soldered in a small PC board, measure in one cubic foot of still air. Figure 11 shows the maximum package power rating for an 8 pin Molded, an 8 pin Ceramic, 14 pin Molded and a 14 pin Ceramic package. The slope of the line corresponds to thermal resistance  $(\phi_{\rm JA} = \Delta P/\Delta T)$ .

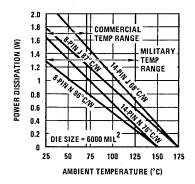


FIGURE 11. Maximum Package Power Rating

The maximum allowable junction temperature for ceramic packages is 175°C; operation above this temperature will reduce the reliability and life of the device below an acceptable level. At a temperature of 500°C the aluminum metallization paths on the die start to melt. The maximum allowable junction temperature for a molded device is 150°C, operations above this may cause the difference in thermal expansion between the molding compound and package lead frame to sheer off the wire bonds from the die to the package lead. The industry standard for a molded device is 150°C, but National further recommends operation below 135°C if the device in its application will encounter a lot of thermal cycling (such as powered on and off over its life).

The way to determine the maximum allowable power dissipation from Figure 11, is to project a line from the maximum ambient temperature (T<sub>A</sub>) of the application vertically (shown dotted in Figure 12), until

the line intercepts the diagonal line of the package type, and then project a line (shown dotted) horizontally until the line intercepts the Power Dissipation Axis (PMAX).

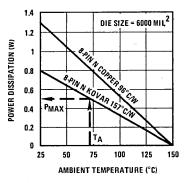


FIGURE 12. Maximum Package Rating Copper vs Kovar Lead Frame Packages

Figure 11 shows that 14 pin packages have less thermal resistance than 8 pin packages; which should be expected since it has more pins to conduct heat and has more surface area. Something that may not be expected is that the Thermal Resistance of the molded devices is comparable to the ceramic devices. The reason for the lower thermal resistance of the molded devices is the Copper lead frame, which is a better thermal conductor than the Kovar lead frame of the ceramic package. Almost all the peripheral drivers made by National Semiconductor are constructed with Copper lead frames (refer to  $\phi_{\rm JA}$  on the specific devices data sheet). The difference between the thermal resistance of Copper and Kovar in a molded package is shown in Figure 12.

Another variance in thermal resistance is the size of the IC die. If the contact area to the lead frame is greater, then the thermal resistance from the Die to the Lead Frame is reduced. This is shown in *Figure 13*. The thermal resistance shown in *Figure 11* corresponds to die that are 6000 mil<sup>2</sup> in area.

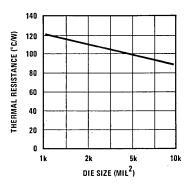


FIGURE 13. Thermal Resistance vs Die Size

In most applications the prime medium for heat conduction is through the device leads to the PC board, but the thermal resistance can be significantly improved by cooling air driven across the surface of the package. The conduction to air is limited by a stagnant film of air at the surface of the package. The film acts as an additional thermal resistance. The thickness of the film is proportional to its resistance. The thickness of the film is reduced by the velocity of the air across the package as shown in Figure 14. In most cases, the thermal resistance is reduced 25% at 250 linear feet/min, above 500 linear feet/min the improvement flattens out.

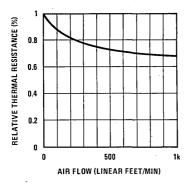


FIGURE 14. Thermal Resistance vs Air Velocity

The thermal resistance can also be improved by connecting the package to the PC board copper or by attaching metal wings to the package. The improvement by these means is outside the control of the IC manufacturer, but is available from the manufacture of the heat sink device. If the IC is mounted in a socket rather than soldered to a PC board, the thermal resistance through the device leads will worsen. In most cases, the thermal resistance is increased by 20%; again this is a variable subject to the specific socket type.

The maximum package rating shown in this note corresponds to a 90% confidence level that the package will have thermal resistance equal to or less than the value shown. The thermal resistance varies  $\pm 5\%$  about the mean due to variables in assembly and package material.

#### **CALCULATIONS OF POWER DISSIPATION**

Most IC devices (such as T<sup>2</sup>L) operate at power levels well below the device package rating, but peripheral drivers can easily be used at power levels that exceed the package rating unknowingly, if the power dissipation isn't calculated. As an example, the DS3654 Ten Bit Printer Driver could dissipate 3 watts (DC and, even more AC), and it is only in a 0.8 watt package. In this example, the device would be destroyed in moments, and may even burn a hole in the PC board it is mounted on. The DS3654 data sheet indicated that the 10 outputs could sink 300 mA with a Vol of 1 volt, but it wasn't intended that all the outputs would be

at the same time, and if so, not for a long period. The use of the DS3654 requires that the power be calculated vs the duty cycle of the outputs.

The DC power dissipation is pretty obvious, but in another example, a customer used the DS3686 relay driver to drive a 6.5 H inductive load. The DS3687 has an internal clamp network to quench the inductive back swing at 60V. At 5 Hz the device dissipates 2 watts, with transient peaks up to 11 watts. After 15 minutes of operation, the driver succumbs to thermal overload and becomes non-functional. The DS3687 was intended for telephone relay, which in most applications switches 20 times a day.

Peripheral driver will dissipate peak power levels that greatly exceed the average DC power. This is due to the capacity of the die and package to consume the transient energy while still maintaining the junction temperature at a safe level. This capacity is shown as a capacitor in Figure 9. In the lab (under a microscope) a device may be observed to glow orange around the parameter of the junction under excessive peak power without damage to the device. Figure 15 shows a plot of maximum peak power vs applied time for the DS3654, and the same information plotted as energy vs applied time. To obtain these curves, the device leakage current when it switches off was used to monitor device limitation. Note in Figure 15 there is a transition in the curve about 10 µs. At this point, the thermal capacity of the die has been exceeded. The thermal delay to the next thermal capacity (the package) was too long, and limited the peak power. These levels are not suggested operating levels, but an example of a Peripheral Driver to handle peak transient power.

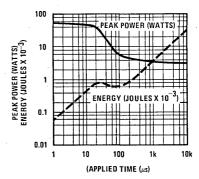


FIGURE 15. Peak Power and Energy vs the Period of Time the Power was Applied

To calculate power dissipation, the only information available to the design engineer is the parametric limits in the device data sheet, and the same information about the load reactance. If the calculations indicate the device is within its limits of power dissipation, then using those parametric limits is satisfactory. If the calculation of power dissipation is marginal, the parametric limits used in the calculations might be worst case at low temperature instead of high temperature

due to a positive temperature coefficient (TC) of resistance. IC resistors and resistors associated with the load generally have a positive Tc. On the other hand, diodes and transistor emitter base voltages have a negative Tc; which may in some circuits negate the effect of the resistors Tc. Peripheral output transistors have a positive TC associated with VOL; while output Darlington transistors have a negative TC at low currents and may be flat at high currents. Figure 16 shows an example of power dissipation vs temperature; note that the power dissipation at the applications maximum temperature (TA) was less than the power dissipation at lower temperatures. Since maximum junction temperature is the concern of the calculation, then maximum ambient temperature power should be used. The junction temperature may be determined by projecting a line (shown dotted in Figure 16), with a slope proportional to  $\phi_{JA}$  back to the horizontal axis (shown as T<sub>J</sub>). If the point is below the curve then T<sub>J</sub> will be less than 150°C. Ty must not exceed the maximum junction temperature for that package type. In this example, T<sub>J</sub> is less than 150°C as required by a molded package. To calculate the power vs temperature, it is necessary to characterize the device parameters vs temperature. Unfortunately, this information is not always provided by IC manufacturers in the device data sheets. A method to calculate ICC vs temperature is to measure a device, then normalize the measurements vs the typical value for ICC in the data sheet, then worst case the measurements by adding 30%. Thirty

percent is normally the worst-case resistor tolerance that IC devices are manufactured to.

# CALCULATION OF OUTPUT POWER WITH AN INDUCTIVE LOAD

For this example, the device output circuit is similar to the DS3654 (10-Bit Printer Solenoid Driver) and the DS3686 and DS3687 (Telephone Relay Driver) as shown in Figure 17. Special features of the circuit type are the Darlington output transistors Q1 and Q2 and the zener diode from the collector of Q2 to the base of Q2. The Darlington output requires very little drive from the logic gate driving it and in turn dissipates less power when the output is turned ON and OFF, than a single saturating transistor output would. The zener diode (DZ) quenches the inductive backswing when the output is turned OFF.

# Device and Load Characteristics Used for Power Calculation

Vol	Output Voltage ON	1.5V
٧c¯	Output Clamp Voltage	65V
VΒ	Load Voltage	30V
RL	Load Resistance	120 Ω
LL	Load Inductance	5h
TON	Period ON	100 ms
TOFF	Period OFF	100 ms
Т	Total Period	200 ms

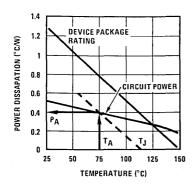


FIGURE 16. IC Power Dissipation vs Temperature

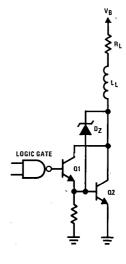


FIGURE 17. Peripheral Driver with Inductive Load

Refer to Figure 18 voltage and current waveforms corresponding to the power dissipation calculated for this example of an inductive load.

PON = Average power dissipation in device output when device is ON during total period (T)

$$\tau = \frac{L_L}{R_L} = \frac{5h}{120 \Omega} = 41.7 \text{ ms}$$

$$I_L = \frac{V_B - V_{OL}}{R_L} = \frac{30 - 1.5}{120} = 237.5 \text{ mA}$$

$$IP = IL (1 - e^{-TON/\tau})$$

$$Ip = 237.5 \text{ mA} \left(1 - e^{-100 \text{ ms}/41.7 \text{ ms}}\right)$$

$$PON = V_{OL} \times I_{L} \times \frac{T_{ON}}{T} \left[ 1 - \int_{0}^{T_{ON}} \frac{e^{-t/\tau} dt}{T_{ON}} \right]$$

$$P_{ON} = V_{OL} \times I_{L} \times \frac{T_{ON}}{T} \left[ 1 - \frac{\tau}{T_{ON}} \left( 1 - e^{-T_{ON}/\tau} \right) \right]$$

$$P_{ON} = 1.5 \times 237.5 \text{ mA} \times \frac{100}{200} \left[ 1 - \frac{41.7}{100} (1 - e^{-\frac{100}{41.7}}) \right]$$

POFF = Average power dissipation in device output when device is OFF during total period (T)

$$I_R = \frac{V_C - V_B}{R_L} = \frac{65 - 30}{120 \Omega} = 291.7 \text{ mA}$$

$$t_X = \tau \ln \left( \frac{I_L + I_R}{I_R} \right)$$

$$t_X = 41.7 \text{ ms } \ln \left( \frac{219.8 + 291.7}{291.7} \right) = 23.1 \text{ ms}$$

$$POFF = V_C \times \frac{t_X}{T} \left[ (I_P + I_R) \int_0^t x \frac{e^{-t/\tau} dt}{t_X} - I_R \right]$$

POFF = 
$$V_C \times \frac{t_X}{T} \left[ (I_P + I_R) \times \frac{\tau}{t_X} (1 - e^{-t_X/\tau}) - I_R \right]$$

$$P_{OFF} = 65 \times \frac{23.1}{200} \left[ (215.9 \text{ mA} + 291.7 \text{ mA}) \frac{41.7}{23.1} \right]$$

POFF = 736 mW

PO = Average power dissipation in device output

In the above example, driving a 120  $\Omega$  inductive load at 5 Hz, the power dissipation exceeded a more simple calculation of power dissipation, which would have been

$$P_O = \frac{V_{OL} (V_B - V_{OL})}{R_L} \times \frac{T_{ON}}{T}$$

$$P_O = \frac{1.5 (30 - 1.5)}{120} \times \frac{100 \text{ ms}}{200 \text{ ms}} = 182.5 \text{ mW}$$

An error 460% would have occurred by not including the reactive load. The total power dissipation must also include other outputs (if the device has more than one output), and the power dissipation due to the device power supply currents. This is an example where the load will most likely exceed the device package rating. If the load is fixed, the power can be reduced by changing the period (T) and duty rate (TON/TOFF).

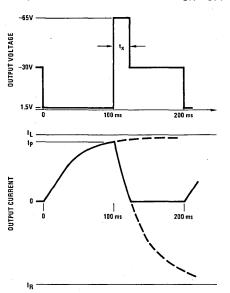


FIGURE 18. Voltage and Current Waveforms Corresponding to Inductive Load.

# CALCULATION OF OUTPUT POWER WITH AN INCANDESCENT LAMP

An incandescent lamp is equivalent to a reactive load. The reactance is related to the period of time required to heat the lamp and the filaments positive temperature coefficient of resistance. Figure 19 shows the transient response for a typical lamp used on instrument panels, and the equivalent electrical model for the lamp. Much like IC packages the lamp has a thermal circuit and its associated propagation delay. This lamp filament has an 8 ms time constant, and a longer 250 ms time constant from the lamp body to ambient. The DC characteristics are shown in Figure 20. Note the knee in the characteristics at 2 volts; this is where power starts to be dissipated in the form of light. This subject is important, since more peripheral drivers are damaged by lamps than any other load.

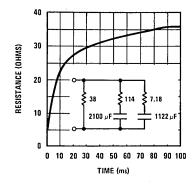


FIGURE 19. Transient Response of an Incandescent Lamp

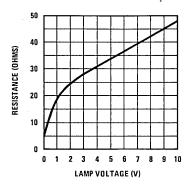


FIGURE 20. DC Characteristics of an Incandescent Lamp

Figure 21 shows the transient response of a driver similar to a DS75451 driving the lamp characterized in Figures 19 and 20. The equivalent load doesn't include the reactance of the lamp base to ambient, which has a 250 ms time constant, since 10 ms to an IC is equivalent to DC. The peak transient current was

1 amp, settling to 200 ms, with an 8 ms time constant. Observe the peak current is clamped at 1 amp, by the sinking ability of the driver; otherwise the peak current may have been 1.2 amps. The DS75451 is only rated at 300 mA, but it is reasonable to assume it could sink 1 amp because of the designed forced  $\beta$  required for switching response and worst case operating temperature.

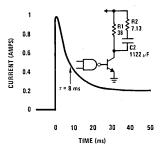


FIGURE 21. Transient Incandescent Lamp Current

Calculation of the energy dissipated by a peripheral driver for the transient lamp current shown in Figure 21 is shown below, and the plot of energy vs time is shown in Figure 22. Figure 22 also includes as a reference the maximum peak energy from Figure 15. It can be seen from Figure 22 that in this example there is a good safety margin between the lamp load and the reference max peak energy. If there were more drivers than one per package under the same load, the margin would have been reduced. Also, if the peripheral driver couldn't saturate because it couldn't sink the peak transient lamp current, then the energy would also reduce the margin of safe operation.

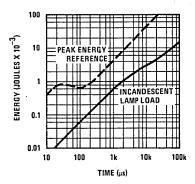


FIGURE 22. Energy vs Time for a Peripheral Driver with an Incandescent Lamp Load

# CALCULATION OF ENERGY IN AN INCANDESCENT LAMP

Energy = 
$$\int_{0}^{t} V_{OL} (I_{R1} + I_{R2}) dt$$
  
 $i_{R1} = \frac{V_B - V_{OL}}{R1} = I_{R1}$ 

$$iR2 = \left(\frac{V_B - V_{OL}}{R2}\right) e^{-t/\tau}$$

= 
$$I_{R2} e^{-t/\tau}$$
  $\tau$  =  $R2C2$ 

Energy = 
$$\int_{0}^{t} V_{OL} (I_{R1} + I_{R2} e^{-t/\tau}) dt$$

= 
$$V_{OL}$$
 [IR1t + IR2 $\tau$  (i - e<sup>-t/ $\tau$</sup> )]

Given: VOL = 0.6V IR1 = 0.2 Amps

IR1 + IR2 = 1 Amp

A common technique used to reduce the 10 to 1 peak to DC transient lamp current is to bias the lamp partially ON, so the lamp filament is warm. This can be accomplished as shown in Figure 23. From Figure 20 it can be seen that the lamp resistance at 0V is 5.7  $\Omega$ , but at 1V the resistance is 18  $\Omega$ . At 1V the lamp doesn't start to emit light. Using a lamp resistance of 100  $\Omega$  and lamp voltage of 1V, RB was calculated to be approximately 100  $\Omega$ . This circuit will reduce the peak lamp current from 1 amp to 316 mA.

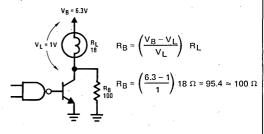


FIGURE 23. Circuit Used to Reduce Peak Transient Lamp Current

#### PERIPHERAL DRIVER SECTION

National Semiconductor has a wide selection of peripheral drivers as shown in the selection guide, *Figure 24*. The DS75451, DS75461, DS3631 and the DS3611 series have the same selection of logic function in an 8-pin package. The DS75461 is a high voltage selection of the DS75451 and may switch slower. The DS3611 and DS3631 are very high voltage circuits and were intended for slow relay applications. The DS3680, DS3686, and DS3687 were intended for 56V telephone relay applications. The DS3654 contains a 10-bit shift register followed by ten 250 mA clamped drivers. The DS3654 was intended for printer solenoid applications.

High current and high voltage peripheral drivers find many applications associated with digital systems, and it is the intention of the application note to insure that reliability and service life of peripheral drivers equal or exceed the performance of the other logic gates made by National.

For additional information, please contact Digital Interface Marketing Manager at National or one of the many field application engineers world wide.

Output High	Latch-Up Voltage	Output Low	Output Low	Propagation Delay	ON Power Supply	Drivers/	Input Compatibility	Logic Function	1	e Number erature Range
Voltage (V)	(Note 3) (V)	Voltage (V)	Current (mA)	Typ (ns)	Current (mA)	Package	(Logic)	(Driver ON)	0°C to +70°C	-55°C to +125°C
30		0.5	100	40	152	8	TTL	Note 5	DP8310	DP7310
30		0.5	100	40	125	8	TTL	Note 6	DP8311	DP7311
20	13.5	0.6	100	70	90	2	TTL	Note 7	DS3616	
65	30	1.5	600		65	4	TTL/LS	NAND	DS3656	
70	35	0.7	600	2430	65	4	TTL/LS	NAND	DS3658	
70	Note 8	1.5	600	2000	80	4	TTL/LS	NAND	DS3668	
70	35	0.7	600		65	-4	TTL/LS	AND	DS3669	
30	20	0.7	300	31	55	2	TTL	AND	DS75450	
30	20	0.7	300	31	55	2	TTL	AND	DS75451	DS55451
30	20	0.7	300	31	55	2	TTL	NAND	DS75452	DS55452
30	20	0.7	300	31	55	2	TTL	OR	DS75453	DS55453
30	20	0.7	300	31	55	2	TTL	NOR	DS75454	DS55454
35	30	0.7	300	33	55	2	TTL	AND	DS75461	DS55461
35	30	0.7	300	33	55	2	TTL	NAND	DS75462	DS55462
35	30	0.7	300	33	55	2	TTL	OR	DS75463	DS55463
35	30	0.7	300	33	55	2	TTL	NOR	DS75464	DS55464
56	40	1.4	300	150	8	2	CMOS	AND	DS3631	DS1631
56	40	1.4	300	150	8	2	CMOS	NAND	DS3632	DS1632
56	40	1.4	300	150	8	2	CMOS	OR	DS3633	DS1633
56	40	1.4	300	150	8	2	CMOS	NOR	DS3634	DS1634
80	50	0.7	300	125	75	2	TTL/CMOS	AND	DS3611	DS1611
80	50	0.7	300	125	75	2	TTL/CMOS	NAND	DS3612	DS1612
80	50	0.7	300	125	75	2	TTL/CMOS	OR	DS3613	DS1613
80	50	0.7	300	125	75	2	TTL/CMOS	NOR	DS3614	DS1614
-2.1	-60	-60	-50	10,000	4.4	. 4	TTL/CMOS	(Note 4)	DS3680	
(Note 1)	56	1.3	300	1000	28	2	TTL/CMOS	NAND	DS3686	
(Note 1)	-56	-1.3	300	1000	28	2	TTL/CMOS	NAND	DS3687	DS1687
13.5	15	V <sub>CC</sub> -1.8	300	150	0.015	2	CMOS	AND	MM74C908, MM74C918	
(Note 1)	45	1.6	250	1000	70	10	(Note 2)	(Note 2)	DS3654	

Note 1: The DS3686, DS3687 and DS3654 contain an internal inductive fly-back clamp circuit connected from the output to ground. As an example, DS3686 driving a relay solenoid connected to 28V would clamp the output voltage fly-back transient at 56V caused by the solenoid's stored inductive current. This clamp protects the circuit output and quenches the fly-back.

Note 2: The DS3654 is a 10-bit shift register followed by 10 enabled drivers. The input circuit is equivalent to a 4k resistor to ground, and the logic input thresholds are 2.8V and 0.8V. The recommended power supply voltage is 7.5V to 9.5V. The circuit can be cascaded to be a 20 or 30-bit shift register.

Note 3: Latch-up voltage is the maximum voltage the output can sustain when switching an inductive load.

Note 4: DS3680 has a differential input circuit.

Note 5: DP8310 inverting, positive edge latching.

Note 6: DP8311 inverting, fall through latch.

Note 7: Bubble memory coil driver.

Note 8: DS3668 35V, latch-up with output fault protection.

FIGURE 24. Peripheral/Power Driver Selection Guide



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# Section 4 Level Translators/ Buffers



TEMPERATUR	E RANGE	DESCRIPTION	PAGE
- 55°C to + 125°C	0°C to +70°C	BESSIII HOI	NUMBER
	DP8480	10k ECL to TTL Level Translator with Latch	4-4
	DP8481	TTL to 10k ECL Level Translator with Latch	4-7
	DP8482	100k ECL to TTL Level Translator with Latch	4-10
	DP8483	TTL to 100k Level Translator with Latch	4-13
DS1630	DS3630	Hex CMOS Compatible Buffer	4-16
*DS7800	DS8800	Dual Voltage Level Translator	4-19
*DS7810	DS8810	Quad 2-Input TTL-to-MOS Interface Gate	4-22
*DS7811	DS8811	Quad 2-Input TTL-to-MOS Interface Gate	4-22
*DS7812	DS8812	Hex TTL-to-MOS Inverter	4-22
*DS78L12	DS88L12	Hex TTL-to-MOS Inverter/Interface Gate	4-25
*DS7819	DS8819	Quad 2-Input TTL-to-MOS Gate	4-27
MM54C901	MM74C901	Hex Inverting TTL Buffer	CMOS
MM54C902	MM74C902	Hex Non-Inverting TTL Buffer	CMOS
MM54C903	MM74C903	Hex Inverting PMOS Buffer	CMOS
MM54C904	MM74C904	Hex Non-Inverting PMOS Buffer	CMOS
MM54C906	MM74C906	Hex Open Drain N-Channel Buffer	CMOS
MM54C907	MM74C907	Hex Open Drain P-Channel Buffer	CMOS

<sup>\*</sup>Also available screened in accordance with MIL-STD-883 Class B. Refer to National Semiconductor's "The Reliability Handbook".



#### LEVEL TRANSLATORS/BUFFERS

INPUT	OUTPUT	OUTDUT CHARACTERISTICS	LOCIC FUNCTION	DEVICE	E NUMBER .	Page
	OUTPUT	OUTPUT CHARACTERISTICS	LOGIC FUNCTION	0°C to +70°C	−55°C to +125°C	No.
10k ECL	TTL	TRI-STATE® Fall Through Latch	Inverting	DP8480		4-4
TTL ,	10k ECL	Gated Fall Through Latch	Inverting	DP8481	•	4-7
100k ECL	TTL	TRI-STATE Fall Through Latch	Inverting	DP8482		4-10
TTL	100k ECL	Gated Fall Through Latch	Inverting	DP8483		4-13
CMOS	CMOS	50 ns Prop. Delay at 500 pF	Hex Buffer	DS3630	DS1630 .	4-16
TTL	PMOS	Open-Collector -30V to 30V	Dual 2-Input Gate	D\$8800	DS7800	4-19
TTL	MOS	Open-Collector 0.4V to 14V	Quad 2-Input Gate	DS8810	DS7810	4-22
TTL	MOS	Open-Collector 0.4V to 14V	Quad 2-Input Gate	DS8811	DS7811	4-22
TTL	MOS	Open-Collector 0.4V to 14V	Hex Inverter	DS8812	DS7812	4-22
TTL	MOS -	Active Pull-Up 0.4V to 14V	Hex Inverter	DS88L12	DS78L12	4-25
TTL	MOS	Open-Collector 0.4V to 14V	Quad 2-Input Gate	DS8819	DS7819	4-27
CMOS	TTL	Active Pull-Up 0.4V @ 2.6 mA	Hex Inverter	MM74C901	MM54C901	CMOS
CMOS	TTL	Active Pull-Up 0.4V @ 3.2 mA	Hex Buffer	MM74C902	MM54C902	CMOS
CMOS	PMOS	Active Pull-Up 0V to 15V	Hex Inverter	MM74C903	MM54C903	CMOS
CMOS	PMOS	Active Pull-Up 0V to 15V	Hex Buffer	MM74C904	MM54C904	CMOS
CMOS	NMOS .	Open Drain OV to 15V	Hex Buffer	MM74C906	MM54C906	CMOS
CMOS	PMOS	Open Drain VCC to VCC - 15V	Hex Buffer	MM74C907	MM54C907	CMOS

# Level Translators/Buffers

# DP8480 10k ECL to TTL Level Translator with Latch

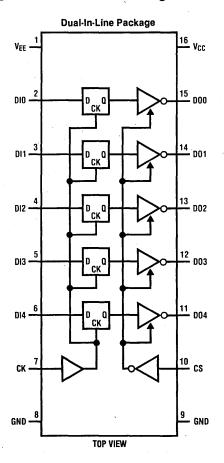
#### **General Description**

This circuit translates ECL input levels to TTL output levels and provides a fall-through latch. The TRI-STATE® outputs are designed to drive large capacitive loads. The clock and chip select inputs are ECL.

#### **Features**

- 16-pin flat-pack or DIP
- TRI-STATE outputs
- ECL control inputs
- 5.5 ns typical propagation delay with 50 pF load
- Outputs are TRI-STATE during power up/down for glitch free operation
- 10k ECL input compatible

#### **Logic and Connection Diagram**



#### **Truth Table**

DI	DO	СК	CS
Н	L	L	L
L	Н	L	L
Х	DO	Н	L
X	Hi-Z	Х	Н

H = high level (most positive)

L = low level (most negative)

X = don't care

Order Number DP8480N or DP8480F See NS Package N16A or F16B

TRI-STATE® is a registered trademark of National Semiconductor Corp.

**Recommended Operating Conditions** 

V<sub>FF</sub>Supply Voltage

V<sub>CC</sub> Supply Voltage

T<sub>A</sub>, Ambient Temperature

 $-5.2V \pm 10\%$ 

 $5.0V \pm 10\%$ 

0°C to 75°C

#### **Absolute Maximum Ratings (Note 1)**

V<sub>EE</sub> Supply Voltage

- 8V V<sub>CC</sub> Supply Voltage 7V GND to V<sub>EE</sub>

**Output Voltage** 

Input Voltage

Maximum Power Dissipation\* at 25°C

Molded Package

1476 mW

5.5V

Storage Temperature - 65°C to 150°C

#### Electrical Characteristics (TTL Logic) Notes 2, 3 and 4

	Parameter	Conditions	Min	Тур	Max	Units
V <sub>OL</sub>	Output Low Voltage	I <sub>OL</sub> = 8 mA			0.5	V
V <sub>OH</sub>	Output High Voltage	I <sub>OH</sub> = -1 mA	2.5			٧ -
I <sub>OD</sub>	Output Low Drive Current	Force 5V with Output Low		150		mA
I <sub>1D</sub>	Output High Drive Current	Force 0V with Output High		- 150		mA
I <sub>OZ</sub>	TRI-STATE Output Current			1		μА
Icc	Supply Current				62.5	mA

#### Electrical Characteristics (ECL Logic) Notes 2 and 3

	Parameter	Conditions	TA	Min	Тур	Max	Units
V <sub>IL</sub>	Input Low Voltage	$V_{EE} = -5.2V$	0°C 25°C 75°C	- 1870 1850 1830		- 1490 - 1475 - 1450	mV
V <sub>IH</sub>	Input High Voltage	V <sub>EE</sub> = -5.2V	0°C 25°C 75°C	- 1145 - 1105 - 1045		- 840 - 810 - 720	mV
l <sub>IL</sub>	Input Low Current				0.5		μΑ
I <sub>IH</sub>	Input High Current				350		μА
IEE	Supply Current					- 50	mA

#### Switching Characteristics Notes 2 and 5

	Parameter	Conditions	Min	Тур	Max	Units
t <sub>CDOL</sub>	Clock to Data Out Low Delay	C <sub>L</sub> = 50 pF		6.75	11.5	ns
t <sub>CDOH</sub>	Clock to Data Out High Delay	C <sub>L</sub> = 50 pF		6.75	11.5	ns
t <sub>DIDOH</sub>	Data In to Data Out High Delay	C <sub>L</sub> = 50 pF		5.5	9.5	ns
t <sub>DIDOL</sub>	Data In to Data Out Low Delay	C <sub>L</sub> = 50 pF		5.5	9.5	ns
ts	Data Set-Up Time	C <sub>L</sub> = 50 pF	3.0	1.0		ns
t <sub>H</sub>	Data Hold Time	C <sub>L</sub> = 50 pF	3.0	1.0		ns
t <sub>CPW</sub>	Clock Pulse Width	C <sub>L</sub> = 50 pF	5.0	3.0		ns
t <sub>ZE</sub>	Delay from Chip Select to Active State from Hi-Z State	$C_L = 50 pF$		8		ns
t <sub>EZ</sub>	Delay from Chip Select to Hi-Z State from Active State	C <sub>L</sub> = 50 pF		8		ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the 0°C to 75°C ambient temperature range in still air and across the specified supply variations. All typical values are for TA = 25°C and nominal supply.

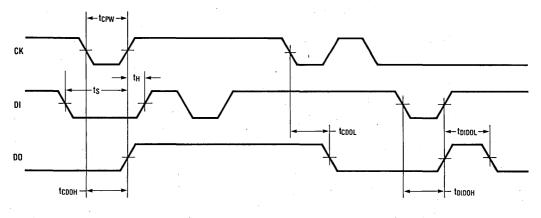
Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative. All voltages are referenced to ground, unless

Note 4: When DC testing I<sub>1D</sub> or I<sub>0D</sub> a 15Ω resistor should be in series with the output. Only one output should be tested at a time.

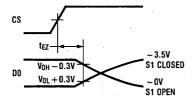
Note 5: Unless otherwise specified, all AC measurements are referenced from the 50% level of the ECL input to the 0.8V level on negative transitions or the 2.4V level on positive transitions of the output. ECL input rise and fall times are 2.0 ns  $\pm$  0.2 ns from 20% to 80%.

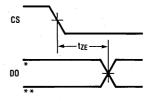
<sup>\*</sup> Derate molded package 11.8 mW/°C above 25°C.

# **Switching Time Waveforms**



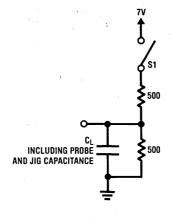
S1 open





\*S1 closed \*\*S1 open

#### **Test Load**



# **Level Translators/Buffers**

#### DP8481 TTL to 10k ECL Level Translator with Latch

#### **General Description**

This circuit translates TTL input levels to ECL output levels and provides a fall-through latch. The outputs are gated with CS providing for wire ORing of outputs. The clock and chip select inputs are ECL.

#### **Features**

- 16-pin flat-pack or DIP
- ECL control inputs
- CS provided for wire ORing of output bus
- 10k ECL I/O compatible
- 4.0 ns typical propagation delay

#### **Logic and Connection Diagram**

# **Dual-In-Line Package** 16 VCC 15 DIO D00 13 DI2 12 DI3 CS GND TOP VIEW

#### **Truth Table**

DI	DO	СК	CS
Н	L	L	Н
L	Н	L	Н
Х	DO	Н	Н
X	L	X	L

H = high level (most positive)

L = low level (most negative)

X = don't care

Order Number DP8481N or DP8481F See NS Package N16A or F16B

#### Absolute Maximum Ratings (Note 1)

V<sub>EE</sub> Supply Voltage -8V

 $\begin{array}{cc} V_{CC} \, \text{Supply Voltage} & 7V \\ \text{Input Voltage (ECL)} & \text{GND to V}_{EE} \end{array}$ 

Input Voltage (下孔) - 1V to 5.5V Output Current 50 mA

Maximum Power Dissipation\* at 25°C

Molded Package 1476 mW Storage Temperature -65°C to +150°C

# **Recommended Operating Conditions**

 $\begin{tabular}{lll} $V_{EE}$ Supply Voltage & $-5.2V \pm 10\% \\ $V_{CC}$ Supply Voltage & $5.0V \pm 10\% \\ $T_A, Ambient Temperature & $0^{\circ}C \ to \ 75^{\circ}C \$ 

#### Electrical Characteristics (TTL Logic) Notes 2 and 3

	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IL</sub>	Input Low Voltage				0.8	V
V <sub>IH</sub>	Input High Voltage		2.0			· - V
I <sub>IL</sub>	Input Low Current	V <sub>IN</sub> = 0.5V		50		μΑ
I <sub>IH</sub>	Input High Current	V <sub>IN</sub> = 2.5V		1.0		μΑ
V <sub>CLAMP</sub>	Input Clamp Voltage	I <sub>IN</sub> = - 12 mA		- 0.8		V .
Icc	Supply Current				30	mA

#### Electrical Characteristics (ECL Logic) Notes 2 and 3

	Parameter	Conditions	T <sub>A</sub>	Min	Тур	Max	Units
V <sub>IL</sub>	Input Low Voltage	V <sub>EE</sub> = -5.2V	0°C 25°C 75°C	1870 1850 1830		- 1490 - 1475 - 1450	mV
V <sub>IH</sub>	Input High Voltage	V <sub>EE</sub> = -5.2V	0°C 25°C 75°C	- 1145 - 1105 - 1045		- 840 - 810 - 720	mV
I <sub>IL</sub>	Input Low Current				0.5		μΑ
I <sub>IH</sub>	Input High Current			3	350		μΑ
V <sub>OL</sub>	Output Low Voltage	V <sub>EE</sub> = -5.2V	0°C 25°C 75°C	- 1870 1850 1830		- 1665 - 1650 - 1625	m∨
V <sub>OH</sub>	Output High Voltage	V <sub>EE</sub> = -5.2V	0°C 25°C 75°C	- 1000 - 960 - 900		- 840 810 720	mV
V <sub>OLC</sub>	Output Low Voltage	V <sub>EE</sub> = -5.2V	0°C 25°C 75°C			- 1645 - 1630 - 1605	mV
V <sub>OHC</sub>	Output High Voltage	V <sub>EE</sub> = -5.2V	0°C 25°C 75°C	- 1020 - 980 - 920			mV
I <sub>EE</sub>	Supply Current					- 90	mA

<sup>\*</sup> Derate molded package 11.8 mW/°C above 25°C.

#### Switching Characteristics Notes 2 and 4

	Parameter	Conditions	Min	Тур	Max	Units
t <sub>CDOL</sub>	Clock to Data Out Low Delay			4.0	6.5	ns
t <sub>CDOH</sub>	Clock to Data Out High Delay			4.0	6.5	ns
t <sub>DIDOH</sub>	Data In to Data Out High Delay			4.0	. 6.5	ns
t <sub>DIDOL</sub>	Data In to Data Out Low Delay			4.0	6.5	ns
ts	Data Set-Up Time to Clock		3.0	1.0		ns
t <sub>H</sub>	Data Hold Time		3.0	1.0		ns
t <sub>CPW</sub>	Clock Pulse Width		5.0	3.0		ns
t <sub>CSDOH</sub>	Chip Select to Data Out High Delay		L	3.0	4.5	ns
t <sub>CSDOL</sub>	Chip Select to Data Out Low Delay			3.0	4.5	ns
t <sub>SCS</sub>	Data Set-Up Time to Chip Select		5.5	3.0		ns

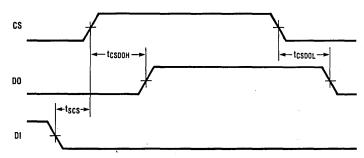
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

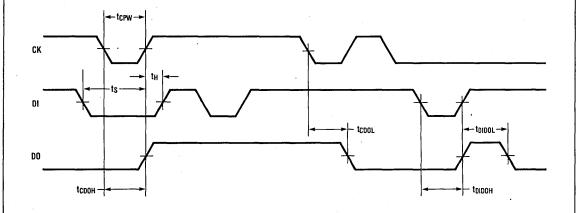
Note 2: Unless otherwise specified, min/max limits apply across the 0°C to 75°C ambient temperature range in still air and across the specified supply variations. All typical values are for 25°C and nominal supply.

Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative. All voltages are referenced to ground, unless otherwise specified.

Note 4: Unless otherwise specified, all AC measurements are referenced from the 1.5V level of the TTL input and to/from the 50% point of the ECL signal and a 500 resistor to -2V is the load. ECL input rise and fall times are 2.0 ns  $\pm$  0.2 ns from 20% to 80%. TTL input characteristic is 0V to 3V with  $t_f = t_f \le 3$  ns measured from 10% to 90%.

#### **Switching Time Waveforms**





#### **Level Translators/Buffers PRELIMINARY**

### DP8482 100k ECL to TTL Level Translator with Latch

#### **General Description**

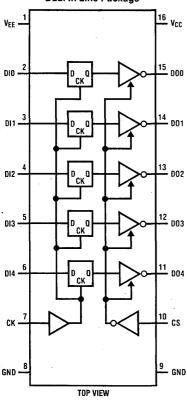
This circuit translates ECL input levels to TTL output levels and provides a fall-through latch. The TRI-STATE® outputs are designed to drive large capacitive loads. The clock and chip select inputs are ECL.

#### **Features**

- 16-pin flat-pack or DIP
- TRI-STATE outputs
- ECL control inputs
- 5.5 ns typical propagation delay with 50 pF load
- Outputs are TRI-STATE during power up/down for glitch free operation
- 100k ECL input compatible

#### **Logic and Connection Diagram**

# **Dual-In-Line Package**



#### **Truth Table**

DI	DO	СК	cs
Н	L	٦	L
L	Н	L	L
Х	DO	Н	L
Х	Hi-Z	Х	Н

H = high level (most positive)

L = low level (most negative)

X = don't care

Order Number DP8482N or DP8482F See NS Package N16A or F16B

TRI-STATE® is a registered trademark of National Semiconductor Corp.

 $-4.5V \pm 7\%$ 

 $5.0V \pm 10\%$ 

0°C to 85°C

**Recommended Operating Conditions** 

V<sub>EE</sub> Supply Voltage

V<sub>CC</sub> Supply Voltage

T<sub>A</sub>, Ambient Temperature

#### Absolute Maximum Ratings (Note 1)

 $\begin{array}{ccc} V_{EE} \, \text{Supply Voltage} & -8 \text{V} \\ V_{CC} \, \text{Supply Voltage} & 7 \text{V} \\ \text{Input Voltage} & \text{GND to V}_{FF} \end{array}$ 

Output Voltage

Maximum Power Dissipation\* at 25°C

Molded Package

1476 mW

5.5V

Storage Temperature  $-65^{\circ}\text{C to} + 150^{\circ}\text{C}$ 

#### Electrical Characteristics (TTL Logic) Notes 2, 3 and 4

	Parameter	Conditions	Min	Тур	Max	Units
$V_{OL}$	Output Low Voltage	I <sub>OL</sub> = 8 mA			0.5	٧
V <sub>OH</sub>	Output High Voltage	I <sub>OH</sub> = -1 mA	2.5			٧
I <sub>OD</sub>	Output Low Drive Current	Force 5V with Output Low		150		mA
I <sub>1D</sub>	Output High Drive Current	Force 0V with Output High		- 150		mA
loz	TRI-STATE Output Current			1		μА
Icc	Supply Current				62.5	mA

#### Electrical Characteristics (ECL Logic) Notes 2 and 3

	Parameter	Conditions	TA	Min	Тур	Max	Units
$V_{IL}$	Input Low Voltage	V <sub>EE</sub> = -4.5V		1810		- 1475	mV
V <sub>IH</sub>	Input High Voltage	V <sub>EE</sub> = -4.5V		- 1165		- 880	mV
I <sub>1L</sub>	Input Low Current			, , ,	0.5		μА
I <sub>IH</sub>	Input High Current				350		μΑ
I <sub>EE</sub>	Supply Current					-50	mA

#### Switching Characteristics Notes 2 and 5

	Parameter	Conditions	Min	Тур	Max	Units
t <sub>CDOL</sub>	Clock to Data Out Low Delay	C <sub>L</sub> = 50 pF		6.75	11.5	ns
t <sub>CDOH</sub>	Clock to Data Out High Delay	C <sub>L</sub> = 50 pF		6.75	11.5	ns
t <sub>DIDOH</sub>	Data In to Data Out High Delay	C <sub>L</sub> = 50 pF		5.5	9.5	ns
t <sub>DIDOL</sub>	Data In to Data Out Low Delay	$C_L = 50 pF$		5.5	9.5	ns
ts	Data Set-Up Time	$C_L = 50 pF$	3.0	1.0		ns
t <sub>H</sub>	Data Hold Time	C <sub>L</sub> = 50 pF	3.0	1.0		ns
t <sub>CPW</sub>	Clock Pulse Width	C <sub>L</sub> = 50 pF	5.0	3.0		ns
tzE	Delay from Chip Select to Active State from Hi-Z State	C <sub>L</sub> = 50 pF		8		ns
t <sub>EZ</sub>	Delay from Chip Select to Hi-Z State from Active State	C <sub>L</sub> = 50 pF		8		ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the 0°C to 85°C ambient temperature range in still air and across the specified supply variations. All typical values are for T<sub>A</sub> = 25°C and nominal supply.

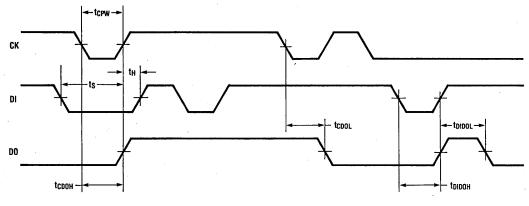
Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative. All voltages are referenced to ground, unless otherwise specified.

Note 4: When DC testing I<sub>1D</sub> or I<sub>0D</sub> a 15Ω resistor should be in series with the output. Only one output should be tested at a time.

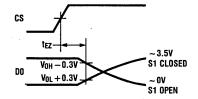
Note 5: Unless otherwise specified, all AC measurements are referenced from the 50% level of the ECL input to the 0.8V level on negative transitions or the 2.4V level on positive transitions of the output. ECL input rise and fall times are 0.7 ns ± 0.1 ns from 20% to 80%.

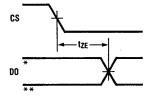
<sup>\*</sup> Derate molded package 11.8 mW/°C above 25°C.

# **Switching Time Waveforms**



S1 open

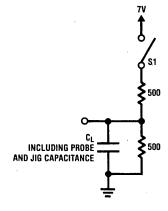




\*S1 closed

\*\*S1 open

#### **Test Load**



#### **Level Translators/Buffers PRELIMINARY**

#### DP8483 TTL to 100k ECL Level Translator with Latch

#### **General Description**

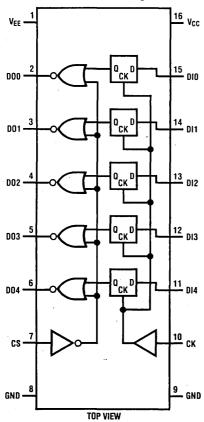
This circuit translates TTL input levels to ECL output levels and provides a fall-through latch. The outputs are gated with CS providing for wire ORing of outputs. The clock and chip select inputs are ECL.

#### **Features**

- 16-pin flat-pack or DIP
- ECL control inputs
- CS provided for wire ORing of output bus
- 100k ECL I/O compatible
- 4.0 ns typical propagation delay

#### **Logic and Connection Diagram**

#### **Dual-In-Line Package**



#### **Truth Table**

DI	DO	СК	cs
Н	L	L	н
L	Н	L	. Н
Х	DO	Н	Н
Х	L	X	L

H = high level (most positive)

L = low level (most negative)

X = don't care

Order Number DP8483N or DP8483F See NS Package N16A or F16B

#### Absolute Maximum Ratings (Note 1)

 $\begin{array}{c} V_{EE} \text{Supply Voltage} & -8 \text{V} \\ V_{CC} \text{Supply Voltage} & 7 \text{V} \end{array}$ 

Input Voltage (ECL) GND to V<sub>EE</sub>
Input Voltage (TTL) -1V to 5.5V

Output Current 50 mA

Maximum Power Dissipation\* at 25°C

Molded Package 1476 mW

Storage Temperature -65°C to +150°C

#### **Recommended Operating Conditions**

 $\begin{array}{lll} V_{EE} & -4.5V \pm 7\% \\ V_{CC} & \text{Supply Voltage} & 5.0V \pm 10\% \\ T_{A}, & \text{Ambient Temperature} & 0^{\circ}\text{C to }85^{\circ}\text{C} \\ \end{array}$ 

#### Electrical Characteristics (TTL Logic) Notes 2 and 3

	Parameter Conditions		Min	Тур	Max	Units	
V <sub>IL</sub>	Input Low Voltage				0.8	V	
V <sub>IH</sub>	Input High Voltage		2.0			٧	
l <sub>IL</sub>	Input Low Current	$V_{IN} = 0.5V$		- 50	-	μΑ	
I <sub>IH</sub>	Input High Current	$V_{IN} = 2.5V$		1.0		μΑ	
V <sub>CLAMP</sub>	Input Clamp Voltage	I <sub>IN</sub> = -12 mA		- 0.8		٧	
Icc	Supply Current				30	mA	

### Electrical Characteristics (ECL Logic) Notes 2 and 3

	Parameter	Conditions	TA	Min	Тур	Max	Units
V <sub>IL</sub>	Input Low Voltage	V <sub>EE</sub> = -4.5V		- 1810		1475	mV
V <sub>IH</sub>	Input High Voltage	V <sub>EE</sub> = -4.5V		<b>– 1165</b>		- 880	mV
I <sub>IL</sub>	Input Low Current				0.5	-	μΑ
I <sub>IH</sub>	Input High Current				350		μΑ
V <sub>OL</sub>	Output Low Voltage	V <sub>EE</sub> = -4.5V		1810	- 1705	- 1620	mV
V <sub>OH</sub>	Output High Voltage	V <sub>EE</sub> = 4.5V		- 1025	<b>–</b> 955	- 880	mV
V <sub>OLC</sub>	Output Low Voltage	V <sub>EE</sub> = -4.5V				- 1610	mV
V <sub>OHC</sub>	Output High Voltage	V <sub>EE</sub> = -4.5V		· – 1035			mV
IEE	Supply Current					- 90	mA

<sup>\*</sup> Derate molded package 11.8 mW/°C above 25°C.

#### Switching Characteristics Notes 2 and 4

	Parameter	Conditions	Min	Тур	Max	Units
t <sub>CDOL</sub>	Clock to Data Out Low Delay			4.0	6.5	ns
t <sub>CDOH</sub>	Clock to Data Out High Delay			4.0	6.5	ns
t <sub>DIDOH</sub>	Data In to Data Out High Delay			4.0	6.5	ns
t <sub>DIDOL</sub>	Data In to Data Out Low Delay			4.0	6.5	ns
ts	Data Set-Up Time to Clock		3.0	1.0		ns
t <sub>H</sub>	Data Hold Time		3.0	1.0		ns
t <sub>CPW</sub>	Clock Pulse Width		5.0	3.0		ns
t <sub>CSDOH</sub>	Chip Select to Data Out High Delay		,	3.0	4.5	ns
t <sub>CSDOL</sub>	Chip Select to Data Out Low Delay			3.0	4.5	ns
t <sub>SCS</sub>	Data Set-Up Time to Chip Select		,5.5	3.0		ns

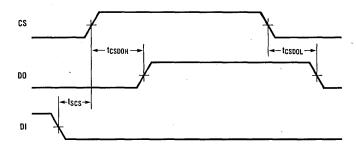
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

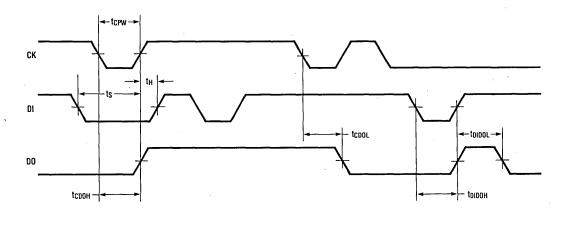
Note 2: Unless otherwise specified, min/max limits apply across the 0°C to 85°C ambient temperature range in still air and across the specified supply variations. All typical values are for 25°C and nominal supply.

Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative. All voltages are referenced to ground, unless otherwise specified.

Note 4: Unless otherwise specified, all AC measurements are referenced from the 1.5V level of the TTL input and to/from the 50% point of the ECL signal and a 500 resistor to -2V is the load. ECL input rise and fall times are 0.7 ns  $\pm$  0.1 ns from 20% to 80%. TTL input characteristic is 0V to 3V with  $t_f = t_f \le 3$  ns measured from 10% to 90%.

#### **Switching Time Waveforms**





# National Semiconductor

## Level Translators/Buffers

# DS1630/DS3630 Hex CMOS Compatible Buffer

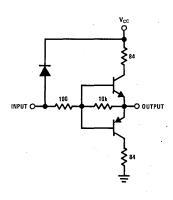
#### **General Description**

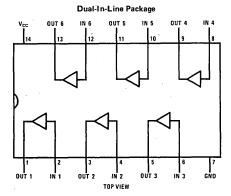
The DS1630/DS3630 is a high current buffer intended for use with CMOS circuits interfacing with peripherals requiring high drive currents. The DS1630/DS3630 features low quiescent power consumption (typically  $50\mu W$ ) as well as high-speed driving of capacitive loads such as large MOS memories. The design of the DS1630/DS3630 is such that  $V_{\rm CC}$  current spikes commonly found in standard CMOS circuits cannot occur, thereby, reducing the total transient and average power when operating at high frequencies.

#### **Features**

- High-speed capacitive driver
- Wide supply voltage range
- Input/output may interface to TTL
- Input/output CMOS compatibility
- No internal transient V<sub>CC</sub> current spikes
- 50μW typical standby power

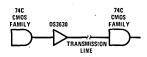
#### **Equivalent Schematic and Connection Diagrams**



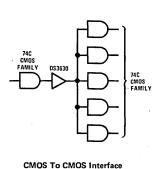


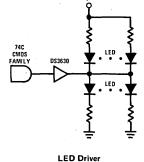
Order Number DS1630J, DS3630J or DS3630N See NS Package J14A or N14A

#### **Typical Applications**



CMOS To Transmission Line Interface





#### Absolute Maximum Ratings (Note 1)

#### **Operating Conditions**

			MIN	MAX	UNITS
Supply Voltage	16V	Supply Voltage (V <sub>CC</sub> )	-3	15	V
Input Voltage Output Voltage Lead Temperature (Soldering, 10 seconds)	16V 16V 300°C	Temperature (T <sub>A</sub> ) DS1630 DS3630	55 0	+125 +70	°C °C

#### **Electrical Characteristics**

(Notes 2 and 3)

PARAMETER	CONDITIONS	CONDITIONS		TYP	MAX	UNITS
I <sub>INH</sub> Logical "1" Input Current	V = V 1 = 400-A	DS1630		90	200	μА
	$V_{IN} = V_{CC}$ , $I_{OUT} = -400\mu A$	DS3630		90	200	μΑ
	$V_{IN} = V_{CC} - 2.0V$ , $I_{OUT} = 16 \text{ mA}$	DS1630		0.5	3.2	mA
	VIN - VCC - 2.0V, 10UT - 10 IIIA	DS3630		0.5	1.5	mA
I <sub>INL</sub> Logical "0" Input Current	V 0.4V 1 40 A	DS1630		-0.15	-1	mA
	$V_{IN} = 0.4V$ , $I_{OUT} = 16 \text{ mA}$	DS3630		V <sub>CC</sub> -150	-800	μΑ
V <sub>OH</sub> Logical "1" Output Voltage	V <sub>IN</sub> = V <sub>CC</sub> , I <sub>OUT</sub> = -400μA	DS1630	V <sub>cc</sub> -1	V <sub>cc</sub> -0.75		٧
		DS3630	V <sub>CC</sub> -0.9	V <sub>CC</sub> -0.75		٧
	$V_{IN} = V_{CC} - 0.4V$ , $I_{OUT} = 16 \text{ mA}$	DS1630	V <sub>CC</sub> -2.5	V <sub>cc</sub> -2.0		V
	V <sub>IN</sub> = V <sub>CC</sub> = 0.4V, 10UT = 10 IIIA	DS3630	V <sub>cc</sub> -2.5	V <sub>cc</sub> -2.0		V
V <sub>OL</sub> Logical "0" Output Voltage	100.0	DS1630		0.75	1	٧
	$V_{1N} = 0V$ , $I_{OUT} = 400\mu A$	DS3630		0.75	0.9	٧
	V = 0V   = 10 = 1	DS1630		0.95	1.3	V
	V <sub>IN</sub> = 0V, I <sub>OUT</sub> = 16 mA	DS3630		0.95	1.3	٧
	V = 0.4V   = 16 = A	DS1630		1.2	1.6	٧
•,	$V_{1N} = 0.4V$ , $I_{OUT} = 16 \text{ mA}$	DS3630		1.2	1.5	V

# Switching Characteristics $V_{CC} = 5.0V$ , $T_A = 25^{\circ}C$ unless otherwise specified

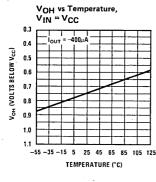
PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd0</sub> Propagation Delay to a Logical "0"	C <sub>L</sub> = 50 pF		30	45	ns
	C <sub>L</sub> = 250 pF		40	60	ns
	C <sub>L</sub> = 500 pF		50	75	ns
t <sub>pd1</sub> Propagation Delay to a Logical "1"	C <sub>L</sub> = 50 pF		15	25	ns
	C <sub>L</sub> = 250 pF		35	50	ns
	C <sub>L</sub> = 500 pF		50	75	ns

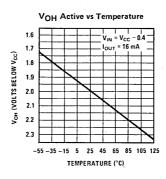
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

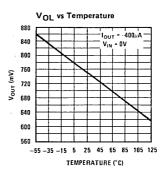
Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS1630 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS3630. All typicals are given for  $V_{CC} = 5.0V$  and  $T_{A} = 25^{\circ}$ C.

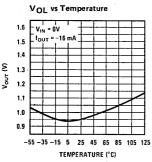
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

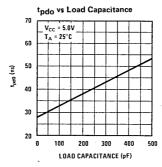
#### **Typical Performance Characteristics**

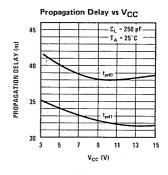


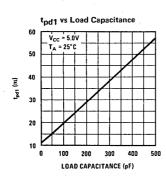


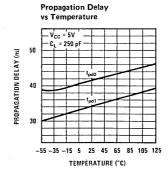




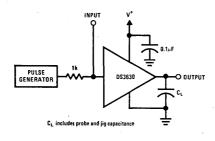


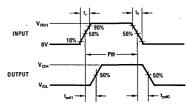






### **AC Test Circuit and Switching Time Waveforms**





Pulse Generator characteristics: PRR = 1.0 MHz, PW = 500 ns, t, =  $\rm t_f < 10$  ns,  $\rm V_{IN}$  = 0 to  $\rm V_{CC}$ 

#### **Level Translators/Buffers**



## DS7800/DS8800 Dual Voltage Level Translator

#### **General Description**

The DS7800/DS8800 are dual voltage translators designed for interfacing between conventional TTL or LS voltage levels and those levels associated with high impedance junction or MOS FET-type devices. The design allows the user a wide latitude in his selection of power supply voltages, thus providing custom control of the output swing. The translator is especially useful in analog switching; and since low power dissipation occurs in the "off" state, minimum system power is required.

#### **Features**

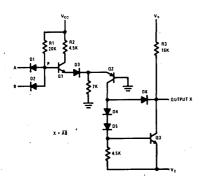
- 31 volt (max) output swing
- 1 mW power dissipation in normal state
- Standard 5V power supply
- Temperature range: DS7800

DS8800

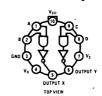
-55°C to +125°C  $0^{\circ}$ C to  $+70^{\circ}$ C

Compatible with all MOS devices

#### Schematic and Connection Diagrams



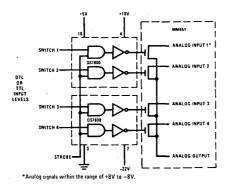
#### Metal Can Package



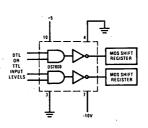
Order Number DS7800H or DS8800H See NS Package H10C

#### **Typical Applications**

#### 4-Channel Analog Switch



#### Bipolar to MOS Interfacing



#### **Absolute Maximum Ratings** (Note 1) **Operating Conditions** MAX UNITS Supply Voltage (VCC) V<sub>CC</sub> Supply Voltage 7.0V DS7800 V2 Supply Voltage -30V 4.5 5.5 DS8800 V3 Supply Voltage 30V 4.75 5.25 V3-V2 Voltage Differential 40V Temperature (TA) Input Voltage 5.5V -55 DS7800 +125 °C Storage Temperature Range -65°C to +150°C DS8800 +70 Lead Temperature (Soldering, 10 seconds) 300°C Maximum Power Dissipation\* at 25°C 690 mW Metal Can (TO-5) Package

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIO	ONS	MIN	TYP (NOTE 6)	MAX	UNITS
V <sub>IH</sub>	Logical "1" Input Voltage	V <sub>CC</sub> = Min		2.0			V
V <sub>IL</sub>	Logical "0" Input Voltage	V <sub>CC</sub> = Min	V <sub>CC</sub> = Min			0.8	V
l <sub>IH</sub>	Logical "1" Input Current	V = Max	$V_{CC} = Max$ $V_{IN} = 2.4V$			5	μΑ
		VCC - Max	V <sub>IN</sub> = 5.5V			1	mA
I <sub>IL</sub>	Logical "0" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V			-0.2	, −0.4	mA
loL	Output Sink Current	V <sub>CC</sub> = Min, V <sub>1N</sub> = 2V,	DS7800	1.6			mA
		V3 Open	DS8800	2.3			mA
I <sub>OH</sub>	Output Leakage Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.8V	(Notes 4 and 7)			10	μΑ
Ro	Output Collector Resistor	T <sub>A</sub> = 25°C		11.5	16.0	20.0	kΩ
VoL	Logical "0" Output Voltage	V <sub>CC</sub> = Min, V <sub>IN</sub> = 2.0V	(Note 7)			V <sub>2</sub> + 2.0	V
I <sub>CC(MAX)</sub>	Power Supply Current Output "ON"	V <sub>CC</sub> = Max, V <sub>IN</sub> = 4.5V (Note 5)			0.85	1.6	mA
I <sub>CC(MIN)</sub>	Power Supply Current Output "OFF"	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0V (	Note 5)	,	0.22	0.41	mA

#### Switching Characteristics T<sub>A</sub> = 25°C, nominal power supplies unless otherwise noted

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd0</sub>	Transition Time to Logical "0" Output	T <sub>A</sub> = 25°C, C = 15 pF (Note 8)	25	70	125	ns
t <sub>pd1</sub>	Transition Time to Logical "1" Output	T <sub>A</sub> = 25°C, C = 15 pF (Note 9)	25	62	125	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DS7800 and across the 0°C to +70°C range for the DS8800.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Current measured is drawn from V<sub>3</sub> supply.

Note 5: Current measured is drawn from V<sub>CC</sub> supply.

Note 6: All typical values are measured at  $T_A = 25^{\circ}$  C with  $V_{CC} = 5.0$ V,  $V_2 = -22$ V,  $V_3 = +8$ V.

Note 7: Specification applies for all allowable values of V2 and V3.

Note 8: Measured from 1.5V on input to 50% level on output,

Note 9: Measured from 1.5V on input to logic "0" voltage, plus 1V.

<sup>\*</sup>Derate metal can package 4.6 mW/°C above 25°C.

#### Theory of Operation

The two input diodes perform the AND function on TTL input voltage levels. When at least one input voltage is a logical "0", current from  $V_{CC}$  (nominally 5.0V) passes through  $R_1$  and out the input(s) which is at the low voltage. Other than small leakage currents, this current drawn from  $V_{CC}$  through the 20  $k\Omega$  resistor is the only source of power dissipation in the logical "1" output state.

When both inputs are at logical "1" levels, current passes through  $R_1$  and diverts to transistor  $\Omega_1$ , turning it on and thus pulling current through  $R_2$ . Current is then supplied to the PNP transistor,  $\Omega_2$ . The voltage losses caused by current through  $\Omega_1$ ,  $D_3$ , and  $\Omega_2$  necessitate that node P reach a voltage sufficient to overcome these losses before current begins to flow. To achieve this voltage at node P, the inputs must be raised to a voltage level which is one diode potential lower than node P. Since these levels are exactly the same as those experienced with conventional TTL, the interfacing with these types of circuits is achieved.

Transistor  $Q_2$  provides "constant current switching" to the output due to the common base connection of  $Q_2$ . When at least one input is at the logical "0" level, no current is delivered to  $Q_2$ , so that its collector supplies essentially zero current to the output stage. But when both inputs are raised to a logical "1" level current is supplied to  $Q_2$ .

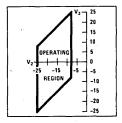
#### Selecting Power Supply Voltage

The graph shows the boundary conditions which must be used for proper operation of the unit. The range of operation for power supply  $V_2$  is shown on the X axis. It must be between -25V and -8V. The allowable range for power supply  $V_3$  is governed by supply  $V_2$ . With a value chosen for  $V_2$ ,  $V_3$  may be selected as any value along a vertical line passing through the  $V_2$  value and terminated by the boundaries of the operating region. A voltage difference between power supplies of at least 5V should be maintained for adequate signal swing.

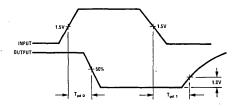
Since this current is relatively constant, the collector of  $\Omega_2$  acts as a constant current source for the output stage. Logic inversion is performed since logical "1" input voltages cause current to be supplied to  $\Omega_2$  and to  $\Omega_3$ . And when  $\Omega_3$  turns on the output voltage drops to the logical "0" level.

The reason for the PNP current source,  $Q_2$ , is so that the output stage can be driven from a high impedance. This allows voltage  $V_2$  to be adjusted in accordance with the application. Negative voltages to -25V can be applied to  $V_2$ . Since the output will neither source nor sink large amounts of current, the output voltage range is almost exclusively dependent upon the values selected for  $V_2$  and  $V_3$ .

Maximum leakage current through the output transistor  $Q_3$  is specified at 10  $\mu A$  under worst-case voltage between  $V_2$  and  $V_3$ . This will result in a logical "1" output voltage which is 0.2V below  $V_3$ . Likewise the clamping action of diodes  $D_4$ ,  $D_5$ , and  $D_6$ , prevents the logical "0" output voltage from falling lower than 2V above  $V_2$ , thus establishing the output voltage swing at typically 2 volts less than the voltage separation between  $V_2$  and  $V_3$ .



#### **Switching Time Waveforms**



# National Semiconductor

#### **Level Translators/Buffers**

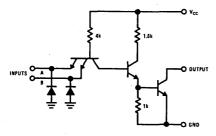
# DS7810/DS8810 Quad 2-Input TTL-MOS Interface Gate DS7811/DS8811 Quad 2-Input TTL-MOS Interface Gate DS7812/DS8812 Hex TTL-MOS Inverter

#### **General Description**

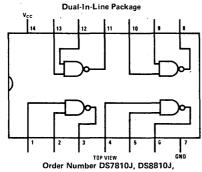
These Series 54/74 compatible gates are high output voltage versions of the DM5401/DM7401 (SN5401/SN7401), DM5403/DM7403 (SN5403/SN7403), and DM5405/DM7405 (SN5405/SN7405). Their open-collector outputs may be "pulled-up" to +14 volts in the logical "1" state thus providing guaranteed interface between TTL and MOS logic levels.

In addition the devices may be used in applications where it is desirable to drive low current relays or lamps that require up to 14 volts.

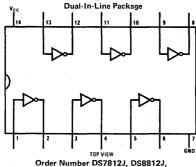
#### **Schematic and Connection Diagrams**



#### DS7810/DS8810, DS7811/DS8811

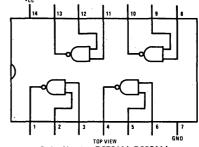


or DS8810N See NS Package J14A or N14A



DS7812W or DS8812N See NS Package J14A, N14A or W14A INPUT O OUTPUT

DS7812/DS8812
Dual-In-Line Package



Order Number DS7811J, DS8811J, DS7811W or DS8811N See NS Package J14A, N14A or W14A

#### **Absolute Maximum Ratings** (Note 1) **Operating Conditions** UNITS MAX Supply Voltage (VCC) 7V V<sub>CC</sub> Input Voltage 5.5V DS78XX 4.5 5.5 14V Output Voltage DS88XX 4.75 5.25 ٧ -65°C to +150°C Storage Temperature Range Temperature (T<sub>A</sub>) Maximum Power Dissipation\* at 25°C °C -55 +125 Cavity Package 1254 mW DS78XX °C +70 Molded Package 1106 mW DS88XX Lead Temperature (Soldering, 10 seconds) 300°C

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
V <sub>CLAMP</sub>	Input Diode Clamp Voltage	V <sub>CC</sub> = 5.0V, T	<sub>A</sub> = 25°C, I <sub>IN</sub> = -12 mA			-1.5	V
V <sub>IH</sub>	Logical "1" Input Voltage	V <sub>CC</sub> = Min		2.0		,	V
V <sub>IL</sub>	Logical "0" Input Voltage	V <sub>CC</sub> = Min				0.8	V
I <sub>OH</sub>	Logical "1" Output Current	V <sub>CC</sub> = Min, V <sub>OUT</sub> = 10V	$V_{IN} = 0.8V$ $V_{IN} = 0.0V$	_		250 40	μA μA
IOL	Logical "O" Output Current	V <sub>CC</sub> = Min, V <sub>IN</sub> = 2.0V, V <sub>OUT</sub> = 0.4V		16			mA
V <sub>OH</sub>	Logical "1" Output Breakdown Voltage	V <sub>CC</sub> = Min, V <sub>IN</sub> = 0V, I <sub>OUT</sub> = 1 mA		14			V
V <sub>OL</sub>	Logical "0" Output Voltage	V <sub>CC</sub> = Min, V <sub>I</sub>	<sub>N</sub> = 2.0V, I <sub>OUT</sub> = 16 mA			0.4	V
I <sub>IH</sub>	Logical "1" Input Current	V <sub>CC</sub> = Max	V <sub>IN</sub> = 2.4V V <sub>IN</sub> = 5.5V			40 1	μA mA
I <sub>IL</sub>	Logical "0" Input Current	V <sub>CC</sub> = Max, V	<sub>IN</sub> = 0.4V		-	-1.6	mA
I <sub>CC(MAX)</sub>	Logical "0" Supply Current (Each Gate)	V <sub>CC</sub> = Max, V <sub>IN</sub> = 5.0V			3.0	5.1	mA
I <sub>CC(MIN)</sub>	Logical "1" Supply Current (Each Gate)	V <sub>CC</sub> = Max, V	N = 0V		1.0	1.8	mA

#### Switching Characteristics T<sub>A</sub> = 25°C, V<sub>CC</sub> = 5V

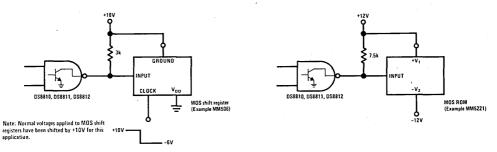
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd0</sub>	Propagation Delay Time to a Logical "0"		4	12	18	ns
t <sub>pd1</sub>	Propagation Delay Time to a Logical "1"	$C_{OUT} = 15 \text{ pF}, R_L = 1 \text{k}$	18	.29	45	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DS7810, DS7811, and DS7812 and across the 0°C to +70°C range for the DS8810, DS8811, and DS8812.

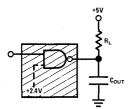
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

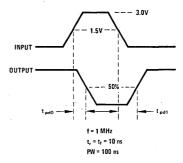
#### Typical Applications



<sup>\*</sup>Derate cavity package 8.36 mW/° C above 25° C; derate molded package 8.85 mW/° C above 25° C.

# AC Test Circuit and Switching Time Waveforms





# National Semiconductor

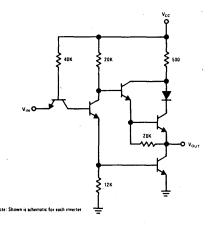
#### Level Translators/Buffers

#### DS78L12/DS88L12 Hex TTL-MOS Inverter/Interface Gate

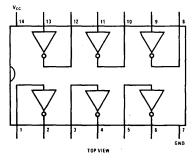
#### **General Description**

The DS78L12/DS88L12 is a low power TTL to MOS hex inverter element. The outputs may be "pulled up" to +14V in the logical "1" state, thus providing guaranteed interface between TTL and MOS logic levels. The gate may also be operated with V<sub>CC</sub> levels up to +14V without resistive pull-ups at the outputs and still providing a guaranteed logical "1" level of  $V_{CC}$  - 2.2V with an output current of -200µA.

#### Schematic and Connection Diagrams



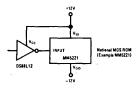
#### **Dual-In-Line Package**



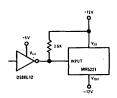
Order Number DS78L12J, DS88L12J Order Number DS88L12N Order Number DS78L12W See NS Package J14A, N14A or W14A

#### **Typical Applications**

TTL Interface to MOS ROM Without Resistive Pull-Up



#### TTL Interface to MOS ROM With Resistive Pull-Up



#### **AC Test Circuits**

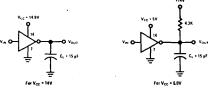
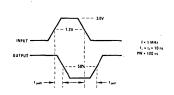


Figure 1

Figure 2

#### **Switching Time Waveforms**



<b>Absolute Maximum Ra</b>	tings (Note 1)	Operating Conditions					
	•		MIN	MAX	UNITS		
Supply Voltage	15V	Supply Voltage (Vcc)					
Input Voltage	5.5V	DS78L12	4.5	5.5	V		
Output Voltage	15V	DS88L12	4.75	5.25	V		
Storage Temperature Range	–65°C to +150°C	Temperature (T <sub>A</sub> )					
Maximum Power Dissipation* at 25°€		DS78L12	-55	125	°c		
Cavity Package	1308 mW	DS88L12	0	70	°C		
Molded Package	1207 mW						
Lead Temperature (Soldering, 10 sec)	300°C						
*Derate cavity package 8.72 mW/°C abov	ve 25°C: derate						

#### Electrical Characteristics (Notes 2 and 3)

molded package 9.66 mW/°C above 25°C.

	PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
VIH	Logical "1" Input Voltage	V <sub>CC</sub> = 14.0V		2.0	1.3		٧
	-	V <sub>CC</sub> = Min		2.0	1.3		V
VIL	Logical "0" Input Voltage	V <sub>CC</sub> = 14.0V			1.3	0.7	٧
		V <sub>CC</sub> = Min			1.3	0.7	٧
VoH	Logical "1" Output Voltage	V <sub>IN</sub> = 0.7V	V <sub>CC</sub> = 14.0V, I <sub>OUT</sub> = -200μA	11.8	12.0		>
		V <sub>IN</sub> = 0.7V	V <sub>CC</sub> = Min, I <sub>OUT</sub> = 200μA	14.5	15.0		>
		V <sub>1N</sub> = 0V, V <sub>CC</sub>	$= Min, I_{OUT} = -5.0\mu A \text{ (Note 6)}$	<u> </u>			٧
VoL	Logical "0" Output Voltage	V <sub>IN</sub> = 2.0V	V <sub>CC</sub> = 14.0V, I <sub>OUT</sub> = 12 mA		0.5	1.0	V
		VIN - 2.0V	V <sub>CC</sub> = Min, I <sub>OUT</sub> = 3.6 mA		0.2	0.4	٧
I <sub>IH</sub>	Logical "1" Input Current	V = 2.4V	V <sub>CC</sub> = 14.0V		<1	20	μΑ
		V <sub>IN</sub> = 2.4V	V <sub>CC</sub> = Max		<1	10	μΑ
		V <sub>IN</sub> = 5.5V	V <sub>CC</sub> = 14.0V		<1	100	μΑ
		VIN - 5.5 V	V <sub>CC</sub> = Max		<sup>'</sup> <1	100	μΑ
t <sub>ill</sub> 1	Logical "0" Input Current	V <sub>IN</sub> = 0.4V	V <sub>CC</sub> = 14.0V		-320	-500	μΑ
		V <sub>IN</sub> = 0.4 V	V <sub>CC</sub> = Max		-100	-180	μΑ
I <sub>sc</sub>	Output Short Circuit Current	V <sub>OUT</sub> = 0V	V <sub>CC</sub> = 14.0V	-10	-25	-50	mA
•		(Note 4)	V <sub>CC</sub> = Max	-3	-8 .	-15	mA
Іссн	Supply Current — Logical "1"		V <sub>CC</sub> = 14.0V		0.32	0.50	mA
	(Each Inverter)	V <sub>IN</sub> = 0V	V <sub>CC</sub> = Max		0.11	0.16	mA
I <sub>CCL</sub>	. Supply Current — Logical "0"	V - 5.05V	V <sub>CC</sub> = 14.0V		1.0	1.5	mA
•	(Each Inverter)	V <sub>IN</sub> = 5.25V	V <sub>CC</sub> = Max		0.3	0.5	mA

# Switching Characteristics T<sub>A</sub> = 25°C, nominal power supplies unless otherwise noted

PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS	
t <sub>pd0</sub>	Propagation Delay to a Logical "0" from Input to Output	T <sub>A</sub> = 25°C	V <sub>CC</sub> = 5.0V V <sub>CC</sub> = 14.0V	(Figure 2) (Figure 1)		27 11	45 20	ns ns
t <sub>pd1</sub>	Propagation Delay to a Logical "1" from Input to Output	T <sub>A</sub> = 25°C	$V_{CC} = 5.0V$ $V_{CC} = 14.0V$	(Figure 2),(Note 5) (Figure 1)		79 34	100 55	ns ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DS78L12 and across the 0°C to +70°C range for the DS88L12.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5:  $t_{pd1}$  for  $V_{CC} = 5.0V$  is dependent upon the resistance and capacitance used.

Note 6:  $V_{OH}$  =  $V_{CC}-1.1V$  for the DS88L12 and  $V_{CC}-1.4V$  for the DS78L12.

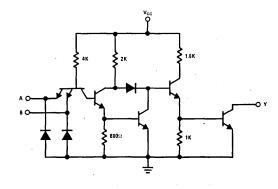
# Level Translators/Buffers



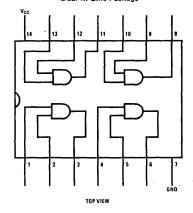
# DS7819/DS8819 Quad 2-Input TTL-MOS AND Gate

The DS7819/DS8819 is the high output voltage version of the SN5409. Its open-collector outputs may be "pulled-up" to 14V in the logical "1" state thus providing guaranteed interface between TTL and MOS logic levels.

#### **Schematic and Connection Diagrams**



#### Dual-In-Line Package



Order Number DS7819J or DS8819J Order Number DS8819N Order Number DS7819W See NS Package J14A, N14A or W14A

#### **Operating Conditions Absolute Maximum Ratings (Note 1)** MAX UNITS Supply Voltage 7.0V Supply Voltage (VCC) Input Voltage 5.5V DS7819 4.5 5.5 Output Voltage 15V DS8819 4.75 5.25 Storage Temperature Range -65°C to +150°C Temperature (TA) Maximum Power Dissipation\* at 25°C DS7819 -55 +125 Cavity Package 1254 mW DS8819 70 Molded Package 1106 mW Lead Temperature (Soldering, 10 sec) 300°C

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	Logical "1" Input Voltage	V <sub>CC</sub> = Min		2.0			V
V <sub>IL</sub>	Logical "0" Input Voltage	V <sub>CC</sub> = Min				0.8	V
I <sub>OH</sub> .	Logical "1" Output Current	V <sub>CC</sub> = Min	V <sub>IN</sub> = 2.0V, V <sub>OUT</sub> = 10V			40.0	μΑ
	·	VCC WIII	$V_{IN} = 4.5V, V_{OUT} = 14V$			1.0	mA
VoL	Logical "0" Output Voltage	V <sub>CC</sub> = Min,	$V_{1N} = 0.8V, I_{OUT} = 16 \text{ mA}$			0.4	V
I <sub>IH</sub>	Logical "1" Input Current	V <sub>CC</sub> = Max	V <sub>IN</sub> = 2.4V			40.0	μΑ
		VCC - Wax	$V_{CC} = IVIAX$ $V_{IN} = 5.5V$			1.0	mA
I <sub>IL</sub>	Logical "0" Input Current	V <sub>CC</sub> = Max,	V <sub>IN</sub> = 0.4V			-1.6	mA
Icch	Logical "1" Supply Current	V <sub>CC</sub> = Max,	V <sub>IN</sub> = 5V		, 11.0	21.0	mA
Iccl	Logical "0" Supply Current	V <sub>CC</sub> = Max,	V <sub>IN</sub> = 0V		20.0	33.0	mA
V <sub>CL</sub>	Input Clamp Voltage	V <sub>CC</sub> = 5.0V,	$T_A = 25^{\circ}C$ , $I_{IN} = -12 \text{ mA}$			-1.5	V

#### Switching Characteristics $T_A = 25^{\circ}C$ , $V_{CC} = 5V$

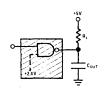
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd0</sub>	Propagation Delay to a Logical "0"	C - 15 - 5 D - 1000		16.0	24.0	ns
t <sub>pd1</sub>	Propagation Delay to a Logical "1"	$C_{OUT} = 15  pF, R_L = 400\Omega$		16.0	32.0	. ns

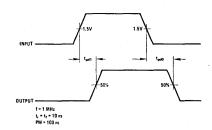
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DS7819 and across the 0°C to +70°C range for the DS8819.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

#### **AC Test Circuit and Switching Time Waveforms**





<sup>\*</sup>Derate cavity package 8.36 mW/° C above 25° C; derate molded package 8.85 mW/° C above 25° C.



# Section 5 **Display Controllers/ Drivers**



TEMPERATURE RANGE		DESCRIPTION	PAGE
- 55°C to + 125°C	0°C to +70°C	DESCRIPTION .	NUMBER
	DP8350	Series CRT Controllers	5-6
	AN-199	A Low Component Count Video Data Terminal	5-30
	•	Using the DP8350 CRT Controller and the INS8080 CPU	
_	AN-212	Graphics Using the DP8350 Series of CRT Controllers	5-44
<del>.</del>	AN-243	Graphics/Alphanumerics Systems Using the DP8350	5-48
-	AN-270	Software Design for a High Speed (38.4 kbaud) Data Terminal	5-76
_	DP-XXX	Advanced Graphic CRT Controller, AGCRTC	5-104
_ ,	DS75491	Quad Segment Driver	5-106
	DS75492	Hex Digit Driver	5-106
*DS55493	DS75493	Programmable Quad Segment Driver	5-109
*DS55494	DS75494	Saturating Hex Digit Driver	5-109
D000494	DS8654		5-113
<del>-</del>	DS8656	8-Output Display Driver	5-113
	DS8664	Print Head Diode Array	5-117
· <del>-</del>	DS8666	14-Digit Decoder/Driver	5-120
_		14-Digit Decoder/Driver (POS Systems)	5-120 5-123
· <del>_</del>	DS8669	Dual Digit, BCD-to-7-Segment LED Decoder/Driver	5-125 5-126
· <del>-</del>	DS8692	8-Output, 350 mA, Transistor Array	5-126 5-126
	DS8693	Printing Calculator Solenoid Driver	
	DS8694	Printing Calculator Solenoid Driver with Clock	5-126
_	DS8859A	Serial Input Hex Latch LED Driver (High Level)	5-133
-	DS8861	MOS, LED 5-Segment Driver	5-136
<del>-</del>	DS8863	MOS, LED 8-Digit Driver	5-136
-	DS8867	8-Segment LED Constant Current Driver	5-139
	DS8869A	Serial Input, Hex Latch LED Driver (Low Level)	5-133
_	DS8870	Hex LED Digit Driver	5-141
	DS8871	8-Digit LED Driver	5-143
_	DS8872	9-Digit LED Driver	5-143
	DS8873	9-Digit LED Driver, Low Battery Indicator	5-143
-	DS8874	9-Digit Shift Input LED Driver	5-145
<del>-</del>	DS8877	6-Digit LED Driver	5-147
DS7880	DS8880	7-Segment Decoder/Driver	5-149
` —	DS8881	16-Digit Vacuum Fluorescent Grid Driver	5-152
_	DS8884A	7-Segment Decoder/Driver	5-156
_	DS8885	MOS-to-High Voltage Cathode Buffer	5-158
_	DS8887	8-Digit High Voltage Anode Driver	5-160
DS7889	DS8889	8-Segment High Voltage Cathode Driver	5-160
_	DS8891A	6-Digit High Voltage Anode Driver	5-164
DS7897A	DS8897A	8-Digit High Voltage Anode Driver (Low Level)	5-160
_	DS8963	18V DS8863	5-136
	DS8973	9-Digit LED Driver, 5.5V, V <sub>CC</sub>	5-166
_	DS8975	9-Digit LED Driver with Low Battery Indicator	5-166
<del>-</del>	AN-84	Driving 7-Segment Gas Discharge Display Tubes with National Semiconductor Circuits	5-169
<u> </u>	AN-99	Driving 7-Segment LED Displays with	5-173
		National Semiconductor Circuits	22

<sup>\*</sup>Also available screened in accordance with MIL-STD-883 Class B. Refer to National Semiconductor's "The Reliability Handbook".

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#### DP8350 CRT CONTROLLER SERIES SELECTION GUIDE

Item No.		Parameter	DP8 Va	350 lue	DP8352 Value		DP8353 Value	
1	Character Font Size	Dots per Character (Width)	(5	5)	(7	)	(7	')
2	(Reference Only)	Scan Lines per Character (Height)	(7	7)	(9	)	(9	))
3	Character Field Cell	Dots per Character (Width)	7	7	9		9	
4	Size	Scan Lines per Character (Height)	1	0	12		1	2
5	Number of Video Char	acters per Row	80		32	2	8	0
6	Number of Video Char	acter Rows per Frame	2	4	16	<b>)</b>	2	5
7	Number of Video Scan	Lines (Item 4 × Item 6)	24	10	19	2	30	00
8	Frame Refresh Rate (H	iz)	f1 = 60	f0 = 50	f1 = 60	f0 = 50	f1 = 60	f0 = 50
9	Delay after Vertical Bla (Number of Scan Lines	ank Start to Start of Vertical Sync s)	4	30	27	53	0	32
10	Vertical Sync Width (N	_10	10	3	3	3	3	
11	Interval between Vertic (Number of Scan Lines	20	72	68	120	20	84	
12	Total Scan Lines per F	260	312	260	312	320	384	
13	Horizontal Scan Frequ	15.6	kHz	15.6	kHz	19.20 kHz		
14	Number of Character	10	00	50	)	. 10	)2	
15	Character Clock Rate	(Item 13×Item 14)	1.56	MHz	0.78	ИНz	1.9584	MHz
16	Character Time (1 ÷ Ite	em 15)	641	ns	1282 ns		510.	6 ns
17	Delay after Horizontal (Character Times)	Blank Start to Horizontal Sync Start	0		6		5	
18	Horizontal Sync Width	(Character Times)	43		4		9	
19	Dot Frequency (Item 3	× Item 15)	10.92	MHz	7.02 MHz		17.6256 MHz	
20	Dot Time (1 - Item 19)		91.6	3 ns	142.4	l ns	56.7	ns
21	Vertical Blanking Outp (Number of Scan Lines	out Stop before Start of Video s)		1	0		1	
22	Cursor Enable on All S	Scan Lines of a Row? (Yes or No)	Y	es	Ye	s	Ye	es
23	Does the Horizontal S Vertical Sync? (Yes or	ync Pulse Have Serrations during No)	N	lo	Ye	S .	, Z	0
24	Width of Line Buffer Clock Logic "0" State within a Character Time (Number of Dot Time Increments)			4	5			5
25	Serration Pulse Width	, if Used (Character Times)			4		-	
26	Horizontal Sync Pulse	Active State Logic Level (1 or 0)	1		0			1
27	Vertical Sync Pulse Ac	ctive State Logic Level (1 or 0)		)	0		1 .	
28	Vertical Blanking Puls	e Active State Logic Level (1 or 0)		1	1			1

Video Monitor Format: Ball Brothers TV-12, TV-120 or Equivalent. (DP8350)
Video Monitor Format: RS-170-Compatible (Standard American TV). (DP8352)

Video Monitor Format: Motorola M3003 or Equivalent. (DP8353)

Drivers/		gment nA)		MAX			e Number	
Package	Sink* (Common	Source (Common	(V)		Comments		Page No.	
	Anode) Cathode) Input	Supply		0°C to +70°C	-55°C to +125°C			
4		30	10	10	Programmable constant current	DS75493	DS55493	5-109
4	50	50	15	10		DS75491		5-106
5	50	. 50	15	10		DS8861		5-136
6	32		5.5	7	Programmable output, active high latch	DS8859A		5-133
6	32		5.7	7	Programmable output, active low latch	DS8869A		5-133
8		18	10	7	Constant current output	DS8867		5-139
8		50	36	36		DS8654		5-113
14	25		6.6	7	BCD input, dual-display driver	DS8669		5-123

<sup>\*</sup>Digit drivers with output sink capability may be used to drive segments of "common anode" displays

#### LED DISPLAY DIGIT DRIVERS

Drivers/ Package	IO /Digit (mA)		VMAX (V)			Device Number		Page
	Sink (Common Cathode)	Source (Common Anode)	Input	Supply	Comments	0°C to +70°C	-55°C to +125°C	No.
4		50	10	10		DS75491		5-106
6	50		10	10	DS75492 pinout, 4.5V to 9V systems	DS8877		5-147
6	150		10	10	Enable control	DS75494	DS55494	5-111
6	250		10	10		DS75492		5-106
6	350		10	10	DS75492 pinout, Darlington output	DS8870		5-141
8	40		11	11		DS8871		5-143
. 8	350		25	25	Open-collector saturating outputs	DS8692	-	5-126
8	500		15	10 -		DS8863		5-136
	500		23	18		DS8963		5-136
		- 50	36	36		DS8654		5-113
9	40		11	11		DS8872		5-143
	40		11	11	Low battery indicator	DS8873		5-143
	50		10	10	Serial shift register input	DS8874		5-145
	100		10	10	3-cell operation—low battery indicator	DS8973		5-166
	100		10	10	No low battery indicator	DS8975		5-166
10	400		9.5	45	Serial input	DS3654	'	3-29
14	80		10	10	On-board osc., 4 line code input, low battery indicator	DS8664		5-117
	80	13	10	10	6 sink, 8 source outputs	DS8666		5-120

### GAS DISCHARGE DISPLAY DRIVERS

Device	Drivers/	C	Devic	Page	
Type	Package	Comments	0°C to +70°C	-55°C to +125°C	No.
Cathode drivers	7	BCD to 7-segment	DS8880	DS7880	5-149
!	7	BCD to 7-segment with comma and DP	DS8884A		5-156
	7	MOS to high voltage cathode buffer	DS8885		5-158
	8	Active high inputs	DS8889	DS7889	5-160
Anode drivers	6	Active low inputs	DS8891A		5-164
	8	Active high inputs	DS8887 ·		5-160
	8	Active low inputs	DS8897A	· DS7897A	5-160

### VACUUM FLUORESCENT DISPLAY DRIVERS

Device	Drivers/		Devic	e Number	Page
Type	Package	Comments	0°C to +70°C	-55°C to +125°C	No.
Ground driver (segments)	8	7-segment plus DP	DS8654		5-113
Anode driver	8	11	DS8654		5-113
(digit)	16	4 line BCD input	DS8881		5-152

### PRINTER DRIVERS

Device	Drivers/	Description	Devic	e Number	Page
Туре	Package	Description	0°C to +70°C	−55°C to +125°C	No.
Mechanical		Relay driver	DS3680		3-44
printer	1	10 hammer serial input driver	DS3654		3-29
		Seiko model 310 print head,	DS8692,		5-126
		interface set	DS8693,		5-126
,			DS8694	ĺ	5-126
Thermal		8-digit driver	DS8654		5-113
printer		Diode matrix	DS8656	}	5-113

# National Semiconductor

### **Display Controllers/Drivers**

### **DP8350 Series CRT Controllers**

### **General Description**

The DP8350 Series of CRT Controllers are single-chip bipolar (I<sup>2</sup>L technology) circuits in a 40-pin package. They are designed to be dedicated CRT display refresh circuits. Three standard products are available, designated DP8350, DP8352, DP8353. Custom devices, however, are available in a broad range of mask programmable options.

The CRT Controller (CRTC) provides an internal dot rate crystal controlled oscillator for ease of system design. For systems where a dot rate clock is already provided, an external clock may be inputted to the CRTC. In either case system synchronization is made possible with the use of the buffered Dot Rate Clock Output.

The DP8350 Series has 11 character generation related timing outputs. These outputs are compatible for systems with or without line buffers, using character ROMs, or DM86S64-type latch/ROM/shift register circuits.

12 bits (4k) of bidirectional TRI-STATE® character memory addresses are provided by the CRTC for direct interface to character memory.

Three on-chip registers provide for external loading of the row starting address, cursor address, and top-of-page address.

A complete set of video outputs is available including cursor enable, vertical blanking, horizontal sync, and vertical sync.

The DP8350 Series CRTC provides for a wide range of programmablility using internal mask programmable ROMs:

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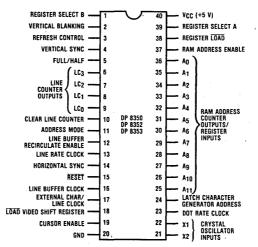
- Character Field (both number of dots/character and number of scan lines/character)
- Characters per Row
- Character Rows per Video Frame
- Format of Video Outputs

The CRTC also provides system sync and program inputs including Refresh Control, Reset, and Address Mode.

### **Features**

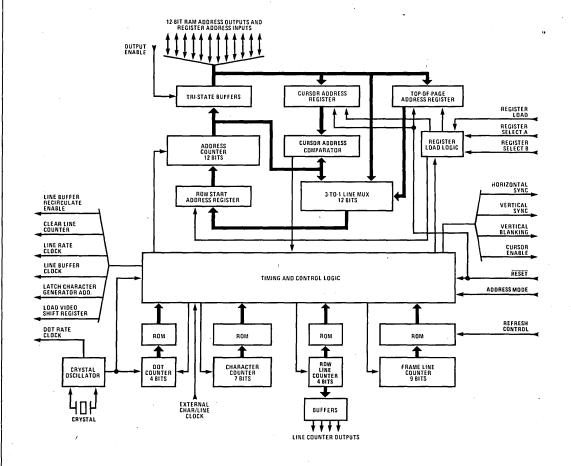
- Internal crystal controlled dot rate oscillator
- External dot rate clock input
- Buffered dot rate clock output
- Timing pulses for character generation
- Character memory address outputs (12 bits)
   Internal cursor address register
- Internal row starting address register
- Internal top-of-page address register (for scrolling)
- Programmable horizontal and vertical sync outputs
- Programmable cursor enable output
- Programmable vertical blanking output
- 2 programmable refresh rates, pin selectable
- Programmable characters/row (128 max.)
- Progammable character field size (up to 16 dots x 16 scan line field size)
- Programmable scan lines/frame (512 max.)
- Programmable character rows/frame
- Single +5V power supply
- Inputs and outputs TTL compatible
- Direct interface with DM86S64 character generator
- Ease of system design/application

### **Connection Diagram**



Order Number DP8350N, DP8352N or DP8353N See NS Package N40A

### **Block Diagram**



#### The Video Display

Discussion of the CRT Controller necessitates an understanding of the video display as presented by a raster scan monitor. The resolution of the data displayed on the monitor screen is a function of the dot size. As shown in Figure 1, the dot size is determined by the frequency of the system dot clock. The visible size of the dot can be modified to less than 100% by external gating of the serial video data. The CRT Controller organizes the dots

into cell groupings that define video rows. These cells are accessed by a specific horizontal address output (4096 maximum) and are resolved by a row scan-line-counter output (16 maximum) as shown in Figure 2. The relation of the video portion of a frame to the horizontal blanking and vertical blanking intervals is shown in Figure 3 in a two-dimensional format.

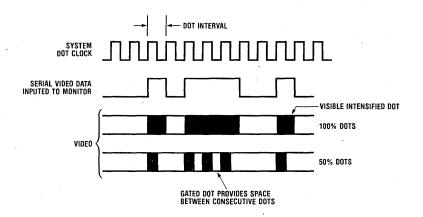


Figure 1. Dot Definition

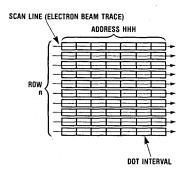


Figure 2. Character Cell Definition (Example Shown is a 7 × 10 Character Cell)

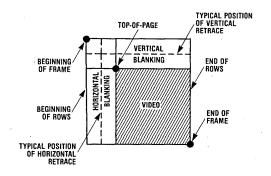


Figure 3. Frame Format Definition

#### Character Generation/Timing Outputs

The CRT controller provides 11 interface timing outputs for line buffers, character generator ROMs, DM86S64-type latch/ROM/shift register combination character generators, and system status timing. All outputs are buffered to provide TTL compatible direct interface to popular system circuits such as:

- DM86S64 Series Character Generators
- MM52116 Series Character ROMs
- · DM74166 Dot Shift Register
- MM5034, MM5035 Octal 80-Bit Shift Registers (Line Buffers)

Dot Rate Clock: This output is provided for use in system synchronization and interface to the dot shift register used in character generation. This output is non-inverting with respect to an external clock applied to the X1 oscillator input (see Figure 6). The dot rate clock output exhibits a 50% duty cycle. All CRTC output logic transitions are synchronous with the rising edge of the Dot Rate Clock output.

Latch Character Generator Address (Character Rate Clock): This output provides an active clock pulse at character rate frequency which is active at all times. The rising edge of this pulse is synchronous with the beginning of each character cell. This output is intended for direct interface to character/video generation data latch registers.

Line Rate Clock: This output provides an active clock pulse at scan-line rate frequency (horizontal frequency), which is active at all times. The falling edge of this pulse is synchronous with the beginning of horizontal blanking. This output is intended for direct interface to character generation scan line counters.

Load Video Shift Register: This output provides a character rate signal intended for direct interface to the video dot shift register used in character generation. Active low pulses are outputted only during video time. As a result of the inactive time, horizontal and vertical video blanking can be derived from this output signal.

Clear Line Counter: This output signal is active only during the first scan line of all rows. It exhibits an active low pulse identical and synchronous to the Line Rate Clock and is provided for direct interface to character generation scan line counters.

Line Counter Outputs (LC<sub>0</sub> to LC<sub>3</sub>): These outputs clock at line rate frequency, synchronous with the falling edge of the line rate clock, and provide a consecutive binary count for each scan line within a row. These outputs are provided for system designs that require decoded information indicating the present scan line position within a row. These outputs are always active, however, the next to the last row during vertical blanking will exhibit an invalid line count as a function of internal frame synchronization.

Line Buffer Clock: This output directly interfaces to data shift registers when they are incorporated as line buffers in a system design (see Figure 16). This signal is active at character rate frequency and is intended for shift registers that shift on a falling edge clock. This output is inactive during all horizontal blanking intervals yielding the number of active clocks per scan line equal to the number

of video characters per row. For custom requirements, the duty cycle of this output is mask programmable.

Line Buffer Recirculate Enable: This output is provided to control the input loading mode of the data shift register (line buffer) when used in a system design. The format of this output is intended for shift registers that load external data into the input with the mode control in the low state, and load output data into the input (recirculate) with the mode control in the high state. This output will transition to the low state, synchronous with the line rate clock falling edge, for one complete scan line of each row. The position of this scan line will either be the first scan line of the addressed row, or the last scan line of the previous row depending upon the logic level of the address mode input (pin 11), tabulated in Table 3.

#### Memory Address Outputs/Inputs and Registers

Address Outputs ( $A_0$ - $A_{11}$ ): These 12 address bits (4k) are bi-directional TRI-STATE® outputs that directly interface to the system RAM memory address bus.

In the output mode (enabled), these outputs will exhibit a specific 12-bit address for each video character cell to be displayed on the CRT screen. This 12-bit address increments sequentially at character rate frequency and is valid at the address bus 2 character times prior to the addressed character appearing as video on the CRT screen. This pipelining by 2 characters is provided to allow sufficient time for first, accessing the RAM memory, and second, accessing the character generation memory with the RAM memory data. Since a character cell is comprised of several scan lines of the CRT beam, the sequential address output string for a given video row is identically repeated for each scan line within the row. The starting address for each video scan line is stored within an internal 12-bit register called the Row Start Register. At the beginning of each video scan line, the internal address counter logic is preset with the contents of the Row Start Register (see Figure 4). To accomplish row by row sequential addressing, internal logic updates the Row Start Register at the beginning of the first scan line of a video row with the last address + 1 of the last scan line of the previous video row. Since the number of address locations on the video screen display is typically much less than the 4k dimension of the 12-bit address bus, an internal 12-bit register called the Top Of Page Register, contains the starting address of the first video row. Internal logic loads the contents of this top of page register into the Row Start Register at the beginning of the first scan line of the first video row. The Top Of Page Register is loaded with address zero whenever the Reset input is pulsed to the logic "0" state.

In the input mode (disabled), external addresses can be loaded into the internal 12-bit registers by external control of the register select A, register select B, and register load inputs (see Table 1). As a result of specific external loading of the contents of the Row Start Register, Top Of Page Register, and the Cursor Register, row by row page scrolling, non-sequential row control, and cursor location control, can easily be accomplished.

During the non-video intervals, the address output operation is modified. During all horizontal blanking intervals, the incrementing of the address counter is inhibited and the address count is held constant at the last video address + 1. For example, if a video row has an 80 character cell format and addressing for the video portion of a given scan line starts at address 1, the address counter will increment up through address 81. Address 81 is held constant during the horizontal blanking interval until 3 character times before the next video scan line. At this point, the address counter is internally loaded with the contents of the Row Start Register which may contain address 1 or 81 as a function of internal control. or a new address that was loaded from the external bus. During vertical blanking, however, this loading of the internal address counter with the contents of the Row Start Register is inhibited providing scan line by scan line sequential address incrementing. This allows minimum access time to the CRTC when the address counter outputs are being used for dynamic RAM refresh.

RAM Address Enable Input: At all times the status of the bi-directional address outputs is controlled externally by the logic level of the enable input. A 'low' logic level at this input places the address outputs in the TRI-STATE® (disabled) input mode. A 'high' logic level at this input places the address outputs in the active (enabled) output mode.

Register Load/Select Inputs: When the Register Load input is pulsed to the logic 'low' state, the Top Of Page, Row Start, or Cursor Register will be loaded with a 12-bit address which originates from either the internal address counter or the external address bus (refer to discussion on register loading constraints). The destination register is selected prior to the load pulse by setting the register select inputs to the appropriate state as defined in Table 1.

Table 1. Register Load Truth Table

Register Select A (Pin 39)	Register Select B (Pin 1)	Register Load Input (Pin 38)	Register Loading Destination
0	0	0	No Select
0	1	0	Top-of-Page
1 1	0	0	Row-Start*
1	1	0	Cursor
X	Χ.	1	No Load

\*During the vertical blanking interval, a load to this register is internally routed to the Top-Of-Page register.

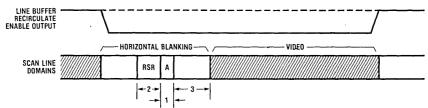
Internal Registers and Loading Constraints: There are 3 internal 12-bit registers that facilitate video screen management with respect to row-by-row page scrolling, non-sequential row control and cursor location. These registers can be loaded with addresses from the external address bus while the address outputs are disabled (RAM address enable inut in the low state), by controlling the register select and load inputs within the constraints of each register.

The Row-Start Register (RSR) holds the starting address for each scan line of the video portion of a frame. The video addressing format is completely determined by the contents of this register. With no external loading, the RSR is automatically loaded by internal control such that row-by-row sequential addressing is achieved. Referring to Figure 4, the RSR is loaded automatically once for each video row during the first addressed scan line. The source of the loaded address is internally controlled such that the RSR load for the first video row comes from the Top-Of-Page Register. The RSR load for all subsequent video rows comes from the address counter which holds the last displayed address + 1. If non-sequential row formatting is desired, the RSR can be loaded externally with a 12-bit address. However, this external load must be made prior to the internal automatic load. Generally speaking, the external load to the RSR should be made during the video domain of the last addressed scan line of the previous row. Figure 4 indicates the internal automatic loading intervals which must be avoided, if the load must be made during the horizontal blanking interval. Once an external address has been loaded to the RSR, the next occurring internal automatic RSR load will be inhibited by internal detection logic. If an external load is made to the RSR during the vertical blanking interval, the 12-bit address is loaded into the Top-Of-Page Register instead of the RSR as a result of internal control. This internal function is performed due to the fact that the address loaded into the RSR for the first video row can only come from the Top-Of-Page Register.

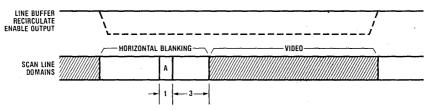
The Top-Of-Page register (TOPR) holds the address of the first character of the first video row. As a function of internal control the contents of this register are loaded into the RSR at the beginning of the first addressed scan line of the first video row (see Figure 4). This loading operation is strictly a function of internal control and cannot be overridden by an external load to the RSR. For this reason, any external load to the RSR during the vertical blanking interval is interpreted internally as a TOPR load. When the Reset input is pulsed to the logic "0" state, the TOPR register is loaded with address zero by internal control. This yields a video page display with the first row of sequential addressing beginning at zero. Page scrolling can be accomplished by externally loading a new address into the TOPR. This loading operation can be performed at any time during the frame prior to the interval where the TOPR is loaded automatically into the RSR (see Figure 4). Once the TOPR has been loaded, it does not have to be accessed again until the contents are to be modified.

The Cursor Register (CR) holds the present address of the cursor location. A true comparison of the address counter outputs and the contents of the CR results in a Cursor Enable output signal delayed by two character times. When the Reset input is pulsed to the logic "0" state, the contents of the CR are set to address zero by internal control. Modifying the contents of the CR is accomplished by external loading at any time during this frame. Typically, loading is performed only during intervals when the address outputs are not actively controlling the video display. Once the CR has been loaded, it does not have to be accessed again until the contents are to be modified.





#### 2nd Through Last Addressed Scan Lines of a Video Row



Note 1: Dimensions are in character time intervals.

Note 2: "A" denotes the interval that the address counter is preset with the contents of the Row Start Register.

Note 3: "RSR" denotes the interval that the Row Start Register is internally loaded with either the contents of the Top-Of-Page Register (1st video row) or the last video address + 1 from the address counter.

Figure 4. Automatic Internal Loading Intervals

#### **Video-Related Outputs**

Horizontal Sync: This output provides the necessary scan line rate sync signal for direct interface to either three-terminal or composite sync monitors. The pulse width, position, and logic polarity are mask programmable, in character time increments, for custom requirements. This output may also be mask programmed to have RS-170 compatible serration pulses during the vertical sync interval (refer to DP8352 format and Figure 15).

**Vertical Sync:** This output provides the necessary frame rate sync signal for direct interface to either three-terminal or composite sync monitors. The pulse width, position, and logic polarity are mask programmable, in scan line increments, for custom requirements.

Cursor Enable: This output provides a signal that is intended to be combined with the video signal to display a cursor attribute which serves as a visual pointer for video RAM location. Internally, the 12-bit address count is continuously being compared with the 12-bit address stored in the Cursor Register. When a true compare is detected, an active high level signal will be present at the Cursor Enable output, delayed by 2 character times after the corresponding address bus output. The signal

is delayed by 2 character times so that it will be coincident with the video information resulting from the corresponding address. Mask programmability allows the cursor enable output signal to be formatted such that a signal will be outputted for all addressed scan lines of a video character cell or any single scan line of that cell. The cursor enable output signal is inhibited during the horizontal and vertical blanking intervals so that video blanking is maintained. When the addressing is advanced by setting the address mode input (pin 11) in the logic "0" state, the cursor enable signal will also be shifted with respect to the scan line count. Specifically, for a character cell with the cursor output active on all addressed scan lines of the cell, the first scan line of the cursor signal will occur at the last scan line count of the previous video row, and the last scan line count of the addressed character cell will have no cursor output signal. This mode of operation gives rise to a unique situation for the first video row where the first addressed scan line of a character cell has no cursor output signal since its advanced scan line position is inhibited by the vertical blanking interval.

#### **CRT System Control Functions**

Refresh Control Input: This input provides a logic level selectable CRT system refresh rate. Typically, this input will select either a 60 Hz or 50 Hz refresh rate to provide geographical marketing flexibility. However, mask programmability provides the capability of a wide range of frequencies for custom requirements. For definition of the input logic truth table and the refresh rate format, refer to Table 2 and the standard device type format tables.

Table 2. Refresh Rate Select Truth Table

Refresh Control (Pin 3)	Frame Refresh Rate					
	Symbol	DP8350	DP8352	DP8353		
1	f1	60 Hz	60 Hz	60 Hz		
0	f0	50 Hz	50 Hz	50 Hz		

Vertical Blanking Output: This output provides a signal that transitions at the end of the last video scan line of the last video row and indicates the beginning of the vertical blanking interval. This signal transitions back to the inactive state during the row of scan lines just prior to the first video row. The transition position within this last row of vertical blanking, as well as the active logic polarity, is a function of the particular device format (item 21 of the format tables) or is mask programmable for custom requirements.

Address Mode: When a system utilizes a line buffer shift register, the first scan line of addressing for a row is used to load the shift register. As a result of this loading operation, addressing for a particular row will not begin accessing the video RAM until the second scan line of addressing for the row. It also follows that the first scan line of a row can only exhibit addressed data for the previous video row that is in the shift register. This offset in addressing becomes a problem for character generation designs that output video on the first scan line of a row (with respect to the line counter outputs). The result is invalid data being displayed for the first scan line. One solution would be to utilize a character generation design that began outputting video on the second scan line of a row. However, since most single chip character generators begin video on the first scan line, the DP8350 series CRT controller provides a pin selectable advanced addressing mode which will compensate for addressing shifts resulting from shift register loading. Referring to Table 3, a high logic level at this input will cause addressing to be coincident with the scan line counter positions of a row, and a low logic level at this input will cause addressing to start on the last scan line counter position of the previous row. This shifted alignment of the addressing, with respect to the designated scan lines of a row, is diagrammed in Figure 5. Characteristically, it follows that, when addressing is advanced by one scan line, the Line Buffer Recirculate Enable output and the Cursor Enable output are also advanced by one scan line. This advanced position of the Cursor Enable output may deserve special consideration depending upon the system design.

Table 3. Address Mode Truth Table

Address Mode Input (Pin 11) (Logic Level)	New Row Addressing At Address Outputs and Line Buffer Recirculate Enable Logic Low Level (Scan Line Position)		
0	Last scan line of previous row		
1	First scan line of row		

Full/Half Row Control: This control input is provided for applications that require the option of half-page addressing. As an example, if the normal video page format is 80 characters/row by 24 rows, setting this input to the logic "0" state will cause the video format to become evenly spaced at 80 characters/row by 12 rows. Specifically, when this input is in the logic "0" state, row addressing is repeated for every other row. This yields successive groups of two rows of identical addressing. The second row of addressing, however, has the Load Video Shiff Register output and the Cursor Enable output internally inhibited to provide the necessary video blanking. Setting this input to the logic "1" state yields normal frame addressing.

External Character/Line Rate Clock: This input is intended to aid testing of the CRTC and is not meant to be used as an active input in a CRT system. When this input is left open, it is guaranteed not to interfere with normal operation.

Reset Input: This input is provided for power-up synchronization. When brought to the logic "0" state, device operation is halted. Internal logic is set at the beginning of vertical blanking, and the Top-Of-Page Register and the Cursor Register are loaded with address zero. When this input returns to the logic "1" state, device operation resumes at the vertical blanking interval followed by video addressing which begins at zero. This input has hysteresis and may be connected through a resistor to V<sub>CC</sub> and through a capacitor to ground to accomplish a power-up Reset. The logic "0" state should be maintained for a minimum of 250 ns.

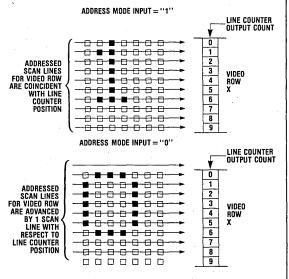


Figure 5. Address Mode Functionality

Crystal Inputs X1 and X2: The "Pierce"-type oscillator is controlled by an external crystal providing parallel resonant operation. Connection of external bias-components is made to pin 22 (X1) and pin 21 (X2) as shown in Figure 6. It is important that the crystal be mounted in close proximity to the X1 and X2 pins to ensure that printed circuit trace lengths are kept to an absolute minimum. Typical specifications for the crystal are shown in Table 4 for each of the standard products, DP8350, DP8352, and DP8353. When customer mask options require higher frequencies, it may be necessary to change the crystal specifications and biasing components. If the CRTC is to be clocked by an external system dot clock, pin 22 (X1) should be driven directly by Schottky family logic while pin 21 (X2) is left open. The typical threshold for pin 22 (X1) is  $V_{CC}/2$ .

Table 4. Typical Crystal Specifications

Doromotor	Specification					
Parameter	DP8350	DP8352	DP8353			
Туре		At-Cut				
Frequency	10.92 MHz	7.02 MHz	17.6256 MHz			
Tolerance	0.005% at 25°C					
Stability	0.01%	from 0°C to	+70°C			
Resonance	Fund	lamental, Pa	rallel			
Maximum Series Resistance	50Ω					
Load Capacitance		20 pF				

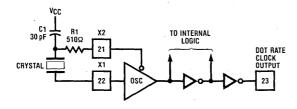


Figure 6. Dot Clock Oscillator Configuration with Typical External Bias Circuitry Shown

Custom Order Mask Programmability: The DP8350 Series CRT controller is available in three standard options designated DP8350, DP8352, and DP8353. The functional format of these devices was selected to meet the typical needs of CRT terminal designs. In order to accommodate specific customer formats, the DP8350 series CRT controller is mask programmable with a diverse range of options available. The items listed in the program table worksheet indicate the available options, while Table 5 tabulates the programming constraints.

Table 5. Mask Programming Limitations

Desig- nation	Parameter	Min. Value	Max. Value					
f <sub>DOT</sub>	Dot Rate Frequency	DC	30 MHz					
f <sub>CHAR</sub>	Character Rate Frequency	DC	2.5 MHz					
1	Line Buffer Clock Logic "0" Width (Item 20 x Item 24)	200 ns						
Item 3	Dots per Character Field Width	4	16					
Item 4	Scan Lines per Character Field	2	16					
Item 12	Scan Lines per Frame		512					
Item 14	Character Times Video		122					
	per Row Blanking	6	123					
Item 11	Scan Lines per Vertical Blanking	(Item 4) + 2						
If the our	If the current anable output, Item 22, is notive an only one							

If the cursor enable output, Item 22, is active on only one line of a character row, then Item 21 value must be either "1" or "0" or equivalent to the line selected for the cursor enable output.

### **DP8350 Series Custom Order Format Table**

This table is provided as a worksheet to aid in determining the programmed configuration for custom mask options. Refer to Table 5 for a list of programming limitations.

Item No.	Parameter			Value				
1	Character Font Size	Dots per Character (Width)						
2	(Reference Only)	Scan Lines per Character (Height)						
3	Observator Field Black Circ	Dots per Character (Width)						
4	Character Field Block Size							
5	Number of Video Characters pe	mber of Video Characters per Row						
6	Number of Video Character Ro	ws per Frame						
7	Number of Video Scan Lines (It	em 4×Item 6)						
8	Frame Refresh Rate (Hz) (two pi	n selectable frequencies allowed) (Item 13 + Item 12)	f1=	f0=				
9	Delay after Vertical Blank start	to start of Vertical Sync (Number of Scan Lines)						
10	Vertical Sync Width (Number of	Scan Lines)						
11	Interval between Vertical Blank (Number of Scan Lines of Video							
12.	Total Scan Lines per Frame (Ite							
13	Horizontal Scan Frequency (Line	e Rate) (kHz) (Item 8 × Item 12)		<del></del>				
14.	Number of Character Times per	Scan Line						
15	Character Clock Rate (MHz) (Ite	m 13 × Item 14)						
16	Character Time (ns) (1 ÷ Item 15	)						
17	Delay after Horizontal Blank sta	urt to Horizontal Sync start (Character Times)						
18	Horizontal Sync Width (Characte	er Times)						
19	Dot Frequency (MHz) (Item 3×II	tem 15)						
20	Dot Time (ns) (1 ÷ Item 19)			<del></del>				
21	Vertical Blanking Output Stop b (Range = Item 4 – 1 line to 0 line	efore start of Video (Number of Scan Lines)						
22		s of a Row? (Yes or No) If not, which Line?						
23	Does the Horizontal Sync Pulse	have Serrations during Vertical Sync? (Yes or No)						
24	Width of Line Buffer Clock logic (Number of Dot Time increment	c "0" state within a Character Time s) (Typically ½ Item 3 rounded up)		· · · · · · · · · · · · · · · · · · ·				
25		Character Times) (See Figure 13)						
26	Horizontal Sync Pulse Active st	ate logic level (1 or 0)						
27	Vertical Sync Pulse Active state	logic level (1 or 0)						
28	Vertical Blanking Pulse Active s	state logic level (1 or 0)						

### **Absolute Maximum Ratings** (Note 1)

Storage Temperature Range

Lead Temperature (soldering, 10 seconds)

Supply Voltage, V<sub>CC</sub> 7.0V
Input Voltage 5.5V
Output Voltage 5.5V

V<sub>CC</sub>, Supply Voltage T<sub>A</sub>, Ambient Temperature

Operating Conditions (Note 6)

Min. Max. Units 4.75 5.25 V 0 +70 °C

**Electrical Characteristics**  $V_{CC} = 5V \pm 5\%$ ,  $T_A = 0$ °C to +70°C (Notes 2, 3, and 5)

-65°C to +150°C

300°C

Parameter		Conditions	Min.	Тур.	Max.	Units
V <sub>IH</sub>	Logic "1" Input Voltage All Inputs Except X1, X2 RESET RESET	`	2.0 2.6			V V
VIL	Logic "0" Input Voltage All Inputs Except X1, X2				0.8	V
V <sub>HYS</sub>	RESET Input Hysteresis			0.4		V
V <sub>clamp</sub>	Input Clamp Voltage All Inputs Except X1, X2	I <sub>IN</sub> = -12 mA		-0.8	-1.2	V.
<b>Ч</b> н	Logic "1" Input Current A <sub>0</sub> -A <sub>11</sub>	Enable Input = 0V, V <sub>CC</sub> = 5.25V, V <sub>IN</sub> = 5.25V		10	100	μΑ
	All Other Inputs Except X1, X2	V <sub>CC</sub> = 5.25V, V <sub>IN</sub> = 5.25V		2.0	20	μА
IIL	Logic "0" Input Current A <sub>0</sub> -A <sub>11</sub>	Enable Input = 0V, V <sub>CC</sub> = 5.25V, V <sub>IN</sub> = 0.5V		-20	-100	μΑ
. [	All Other Inputs Except X1, X2	$V_{CC} = 5.25V, V_{IN} = 0.5V$	-	-20	-100	μΑ
VoH	Logic "1" Output Voltage	$I_{OH} = -100 \mu\text{A}$	3.2	4.1		٧
.		I <sub>OH</sub> = -1 mA	2.5	3.3		٧
VoL	Logic "0" Output Voltage	I <sub>OL</sub> = 5 mA		0.35	0.5	V
los	Output Short Circuit Current	$V_{CC} = 5V$ , $V_{OUT} = 0V$ (Note 4)	10	40	100	mA
Icc	Power Supply Current (Note 10)	V <sub>CC</sub> = 5.25V		220	300	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min./max. limits apply across the 0°C to +70°C temperature range and the 4.75V to 5.25V power supply range. All typical values are for  $T_A = 25$ °C and  $V_{CC} = 5.0$ V and are intended for reference only.

Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max. or min. are so classified on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: Electrical specifications do not apply to pin 17, external char/line clock, as this pin is used for production testing only.

Note 6: Functional operation of device is not guaranteed when operated beyond specified operating condition limits.

Switching Characteristics  $V_{CC} = 5.0V \pm 5\%$ ,  $T_A = 25$ °C (Note 7)

	Parameter	Load Circuit	Notes	Min.	Тур.	Max.	Units
Symmetry	Dot Rate Clock Output High Symmetry With Crystal Control	1		50% – 4	50% – 2	50% + 1	ns
t <sub>pd1</sub>	XI Input to Dot Rate Clock Output Positive Edge	1			17	22	ns
t <sub>pd0</sub>	XI Input to Dot Rate Clock Output Negative Edge	1			21	26	ns
t <sub>D1</sub>	Dot Clock to Load Video Shift Register Negative Edge	1	-		6.0	10	ns
t <sub>D2</sub>	Dot Clock to Load Video Shift Register Positive Edge	1			11	15	ns
t <sub>D3</sub>	Dot Clock to Latch Character Generator Positive Edge	1			8.0	13	ns
t <sub>D4</sub>	Dot Clock to Latch Character Generator Negative Edge	1			6.0	10	ns

### Switching Characteristics (Cont'd.) $V_{CC} = 5.0V \pm 5\%$ , $T_A = 25$ °C (Note 7)

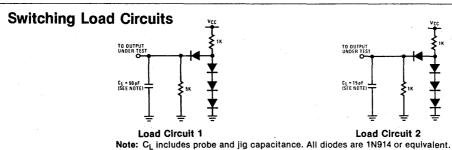
Parameter		Load Circuit	Notes	Min.	Тур.	Max.	Units
t <sub>D2</sub> -t <sub>D3</sub>	Latch Character Generator Positive Edge to Load Video Shift Register Positive Edge	1		0	3.0		ns
t <sub>D5</sub>	Dot Clock to Line Buffer Clock Negative Edge	1			23	35	ns
t <sub>PW1</sub>	Line Buffer Clock Pulse Width	1	8,9	N(DT)	N(DT)+8	N(DT)+12	ns
t <sub>D6</sub>	Dot Clock to Cursor Enable Output Transition	1			24	36	ns
t <sub>D7</sub>	Dot Clock to Valid Address Output	1			15	25	ns
t <sub>D80</sub>	Latch Character Generator to Line Rate Clock Neg. Transition	1	8,10		425 + DT	500 + DT	ns
t <sub>D81</sub>	Latch Character Generator to Line Rate Clock Pos. Transition	1	8,10		300 + DT	400 + DT	ns
t <sub>D90</sub>	Latch Character Generator to Clear Line Counter Neg. Transition	1	8,10		525 + DT	700 + DT	ns
t <sub>D91</sub>	Latch Character Generator to Clear Line Counter Pos. Transition	1	8,10		290 + DT	400 + DT	ns
t <sub>D81</sub> -t <sub>D91</sub>	Clear Line Counter Pos. Transition to Line Rate Clock Pos. Transition	1	10		10	60	ns
t <sub>D10</sub>	Line Rate Clock to Line Counter Output Transition	1			60	120	ns
t <sub>D11</sub>	Line Rate Clock to Line Buffer Recirculate Enable Transition	1			195	300	ns
t <sub>D12</sub>	Line Rate Clock to Vertical Blanking Transition	1			160	300	ns
t <sub>D13</sub>	Line Rate Clock to Vertical Sync Transition	1			220	300	ns
t <sub>D14</sub>	Latch Character Generator to Horizontal Sync Transition	1			96	150	ns
t <sub>S1</sub>	Register Select Set-up Before Register Load Negative Edge			0			ns
t <sub>H1</sub>	Register Select Hold After Register Load Positive Edge			0			ns
t <sub>S2</sub>	Valid Address Input Set-Up Before Register Load Positive Edge			250			ns
t <sub>H2</sub>	Valid Address Hold Time After Register Load Positive Edge			0			ns
t <sub>PW2</sub>	Register Load Required Pulse Width			150	65		ns
t <sub>LZ</sub> , t <sub>HZ</sub>	Delay from Enable Input to Address Output High Impedance State from Logic "0" and Logic "1"	2			15	30	ns
t <sub>ZL</sub> , t <sub>ZH</sub>	Delay from Enable Input to Logic "0" and Logic "1" from Address Output High Impedance State	2			17	30	ns

Note 7: Typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25$ °C and are meant for reference only.

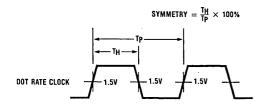
Note 8: "DT" denotes dot rate clock period time, item 20 from option format table.

Note 9: "N" denotes value of item 24 from option format table.

Note 10: Revised since last issue.



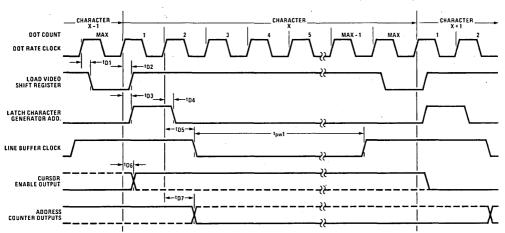
### **Switching Waveforms**



t<sub>r</sub> = t<sub>f</sub> ≤ 10 ns X2 (PIN 21) = 0PEN

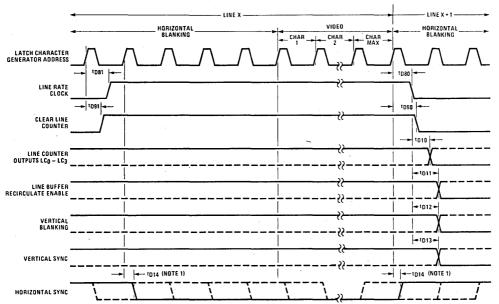
Figure 7. Dot Rate Clock Output Waveform Symmetry with Crystal Control

Figure 8. X1 Input to Dot Rate Clock Output Propagation Delay



Note 1: All measurement points are 1.5V

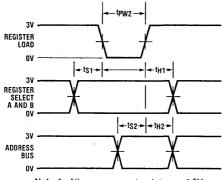
Figure 9. Dot/Character Rate Timing



Note 1: Actual polarity and position of the horizontal sync start and stop points is a function of the particular device format. Note 2: All measurement points are 1.5V.

Figure 10. Character/Line Rate Timing

### Switching Waveforms (cont'd)



Note 1: All measurement points are 1.5V.

Note 2:  $t_r = t_f \le 10 \text{ ns}$ .

Note 3: Address enable (pin 37) = 0V.

Figure 11. Register Select and Load Waveforms

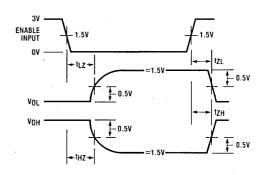
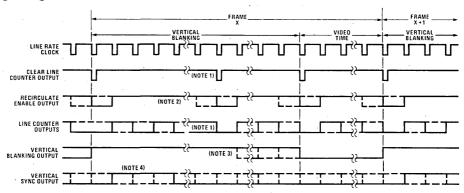


Figure 12. Address Output Enable/Disable Waveforms

### **Timing Diagrams**



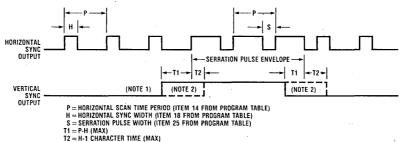
**Note 1:** One full row before start of video the line counter is set to zero state — this provides line counter synchronization in cases where the number of lines in vertical blanking are not even multiples of the number of lines per row.

Note 2: The position of the line buffer recirculate enable logic low level is a function of the logic level of the address mode input (see Table 3).

Note 3: The stop point of the vertical blanking output active signal is a function of device type or custom option, and will always be within one row prior to video.

Note 4: The transition start and stop points of the vertical sync output signal are a function of device type or custom option.

Figure 14. Line/Frame Rate Functional Diagram



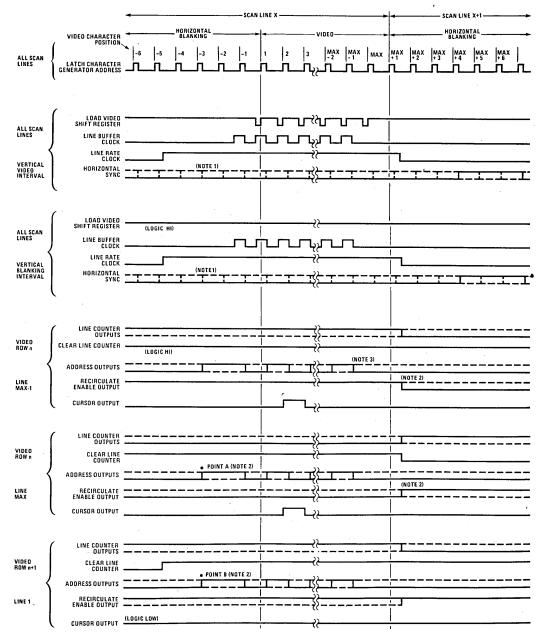
12 - 11-1 GUNUNGTER TIME (MAX)

Note 1: The vertical sync transition point is always coincident with the beginning of horizontal blanking.

Note 2: T1 and T2 intervals represent the range of alignment offset between the vertical sync pulse and the serration pulse envelope and is a function of the horizontal sync position with respect to the beginning of horizontal blanking.

Figure 15. Serration Pulse Format

### Timing Diagrams (cont'd)



Note 1: The horizontal sync output start and stop point positions are a function of device type or custom option.

Note 2: The position of the recirculate enable output logic "0" level is dependent on the state of the address mode input. When address mode = "0", recirculate enable occurs on the max. line of a character row (solid line) and the address counter outputs roll over to the new row address at point A. When address mode = "1", recirculate enable occurs on the first line of a character row (dashed line) and the address counter outputs roll over to the new row address at point B.

Note 3: The address counter outputs clock to the address of the last character of a video row plus 1. This address is then held during the horizontal blanking interval until video minus three character times. At this point the outputs are modified to the contents of the Row Start Register (RSR).

Figure 13. Character/Line Rate Functional Diagram

### **Applications**

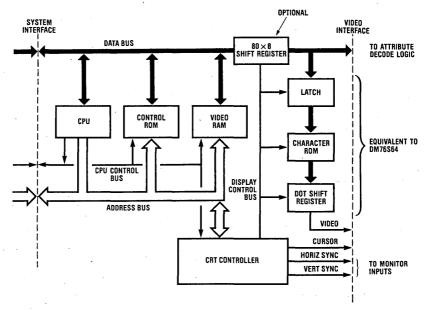


Figure 16. General System Block Diagram

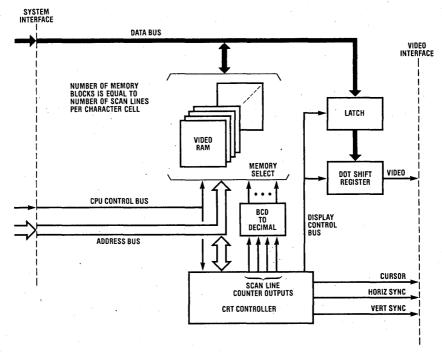


Figure 17. Dot-By-Dot Graphics Block Diagram

### **DP8350 CRT Controller**

Table 6. Characteristic Format

Item No.		Parameter	,	Value			
1	Character Font Size		(5)				
2	(Reference Only)	(7)					
3	Observator Field Call Circ	7					
4	Character Field Cell Size		10				
5	Number of Video Characters per Row 80						
6	Number of Video Character Ro	ws per Frame		24			
7	Number of Video Scan Lines (I	tem 4×Item 6)		240			
8	Frame Refresh Rate (Hz)		f1 = 60	f0 = 50			
9	Delay after Vertical Blank start	4	30				
10	Vertical Sync Width (Number o	f Scan Lines)	10	10			
11	Interval between Vertical Blank (Number of Scan Lines of Vide	20	72				
12	Total Scan Lines per Frame (Ite	260	312				
13	Horizontal Scan Frequency (Lir	15.6 kHz					
14	Number of Character Times pe	100					
15	Character Clock Rate (Item 13:	1.56 MHz					
16	Character Time (1 ÷ Item 15)	641 ns					
17	Delay after Horizontal Blank st	art to Horizontal Sync start (Character Times)	0				
18	Horizontal Sync Width (Charac	ter Times)		43			
19	Dot Frequency (Item 3×Item 1	5)	10.	92 MHz			
20	Dot Time (1 + Item 19)		9	1.6ns			
21	Vertical Blanking Output Stop I	pefore start of Video (Number of Scan Lines)		1			
22	Cursor Enable on all Scan Line	s of a Row? (Yes or No)		Yes			
23	Does the Horizontal Sync Pulse	e have Serrations during Vertical Sync? (Yes or No)		No			
24	Width of Line Buffer Clock logi (Number of Dot Time increment	c "0" state within a Character Time is)		4			
25	Serration Pulse Width, if used (	Character Times)		_			
.26	Horizontal Sync Pulse Active st	ate logic level (1 or 0)		1			
27	Vertical Sync Pulse Active state	e logic level (1 or 0)		0			
28	Vertical Blanking Pulse Active	state logic level (1 or 0)		1			
Video	Monitor Format: Ball Brothers TV	/_12 TV_120 or Equivalent	<u> </u>	<del></del>			

Video Monitor Format: Ball Brothers TV-12, TV-120 or Equivalent.

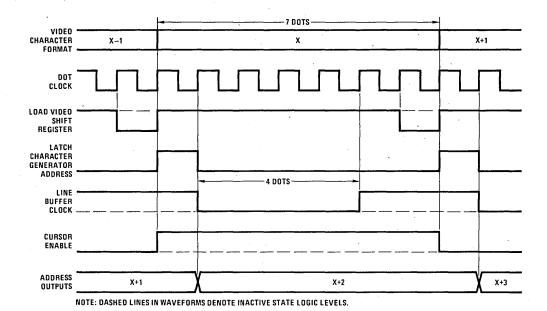


Figure 18. DP8350 Video Character Signals

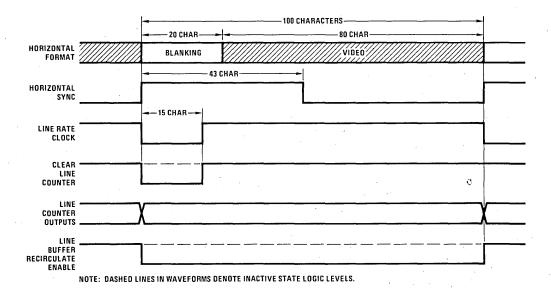


Figure 19. DP8350 Scan Line Signals

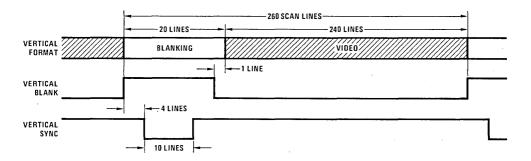


Figure 20. DP8350 60 Hz Refresh Rate Frame Signals

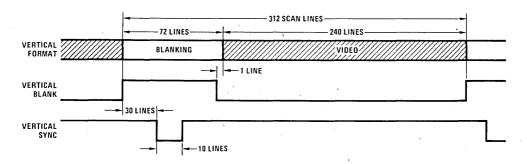


Figure 21. DP8350 50 Hz Refresh Rate Frame Signals

### **DP8352 CRT Controller**

Table 7. Characteristic Format

Item No.		Parameter	V V	/alue			
1	Character Font Size	Dots per Character (Width)	(7)				
2	(Reference Only) Scan Lines per Character (Height) (9)						
3		Dots per Character (Width)	9				
4	Character Field Cell Size	Scan Line per Character (Height)		12			
5	Number of Video Characters p	er Row		32			
6	Number of Video Character Ro	ws per Frame		16			
7	Number of Video Scan Lines (I	tem 4×Item 6)		192			
8	Frame Refresh Rate (Hz)		f1 = 60	f0 = 50			
9	Delay after Vertical Blank start	to start of Vertical Sync (Number of Scan Lines)	27	53			
10	Vertical Sync Width (Number o	f Scan Lines)	3	3			
11	Interval between Vertical Blank (Number of Scan Lines of Vide		68	120			
12	Total Scan Lines per Frame (Ite		260 312				
13	Horizontal Scan Frequency (Line Rate) (Item 8 × Item 12) 15.6 kHz						
14	Number of Character Times pe	50					
15	Character Clock Rate (Item 13	0.78 MHz					
16	Character Time (1 ÷ Item 15)		1282 ns				
17	Delay after Horizontal Blank st	art to Horizontal Sync start (Character Times)	6				
18	Horizontal Sync Width (Charac	ter Times)	4				
19	Dot Frequency (Item 3 × Item 1	5)	7.02 MHz				
20	Dot Time (1 - Item 19)		14	2.4 ns			
21	Vertical Blanking Output Stop	before start of Video (Number of Scan Lines)		0			
22	Cursor Enable on all Scan Line	es of a Row? (Yes or No)		Yes			
23	Does the Horizontal Sync Puls	e have Serrations during Vertical Sync? (Yes or No)		Yes			
24	Width of Line Buffer Clock log (Number of Dot Time incremen	ic "0" state within a Character Time ts)		5			
25	Serration Pulse Width, if used			4			
26	Horizontal Sync Pulse Active s	tate logic level (1 or 0)		0			
27	Vertical Sync Pulse Active stat	e logic level (1 or 0)		0			
28	Vertical Blanking Pulse Active state logic level (1 or 0)						

Video Monitor Format: RS-170-Compatible (Standard American TV).

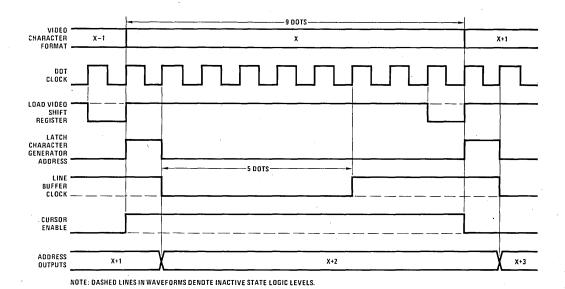


Figure 22. DP8352 Video Character Signals

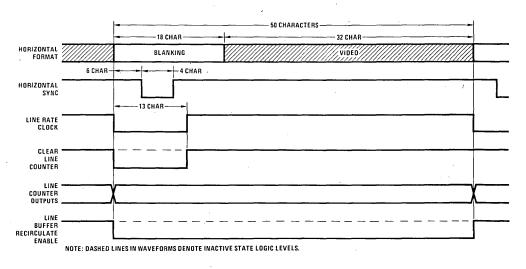


Figure 23. DP8352 Scan Line Signals

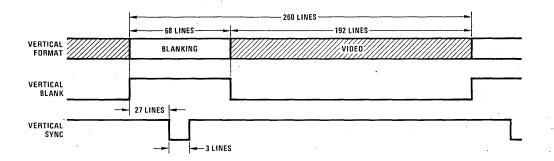


Figure 24. DP8352 60 Hz Refresh Rate Frame Signals

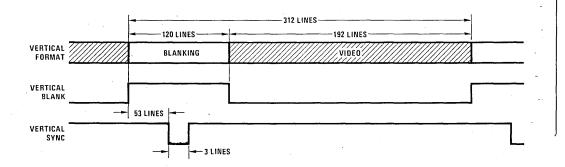


Figure 25. DP8352 50 Hz Refresh Rate Frame Signals

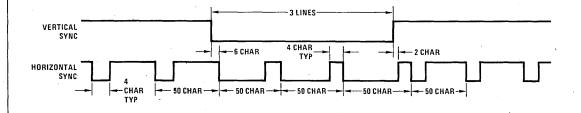


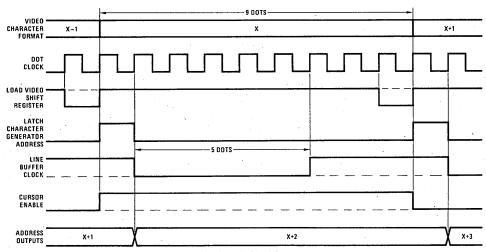
Figure 26. DP8352 Serration Pulse Format

### **DP8353 CRT Controller**

Table 8. Characteristic Format

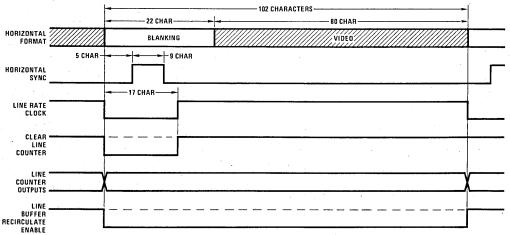
Item No.		Parameter	,	/alue			
1	Character Font Size		(7)				
2	(Reference Only) Scan Lines per Character (Height) (9)						
3	Character Field Cell Size Dots per Character (Width) 9						
. 4	Character Field Cell Size	Scan Line per Character (Height)		12			
5	Number of Video Characters per Row 80						
6	Number of Video Character Ro	ws per Frame _		25			
7	Number of Video Scan Lines (I	tem 4×ltem 6)		300			
8	Frame Refresh Rate (Hz)		f1 = 60	f0 = 50			
9	Delay after Vertical Blank start	to start of Vertical Sync (Number of Scan Lines)	0	32			
10	Vertical Sync Width (Number o	f Scan Lines)	3	3			
11	Interval between Vertical Blank (Number of Scan Lines of Vide	20	84				
12	Total Scan Lines per Frame (Ite	320	384				
13	Horizontal Scan Frequency (Lir	19.20 kHz					
14	Number of Character Times pe	102					
15	Character Clock Rate (Item 13	1.9	584 MHz				
16	Character Time (1 ÷ Item 15)		510.6 ns				
17	Delay after Horizontal Blank st	art to Horizontal Sync start (Character Times)	5				
18	Horizontal Sync Width (Charac	ter Times)		9			
19	Dot Frequency (Item 3×Item 1	5)	17.6	256 MHz			
20	Dot Time (1 ÷ Item 19)		5	6.7ns			
21	Vertical Blanking Output Stop	before start of Video (Number of Scan Lines)		1			
22	Cursor Enable on all Scan Line	s of a Row? (Yes or No)		Yes			
23	Does the Horizontal Sync Puls	e have Serrations during Vertical Sync? (Yes or No)		No			
24	Width of Line Buffer Clock logi (Number of Dot Time incremen	c "0" state within a Character Time ts)		5			
25	Serration Pulse Width, if used	(Character Times)		<u> </u>			
26	Horizontal Sync Pulse Active s	tate logic level (1 or 0)		1			
27	Vertical Sync Pulse Active stat	e logic level (1 or 0)		1			
28	Vertical Blanking Pulse Active	state logic level (1 or 0)		1			
Video	Monitor Format: Motorola M3003	3 or Equivalent.	. 4				

Video Monitor Format: Motorola M3003 or Equivalent.



NOTE: DASHED LINES IN WAVEFORMS DENOTE INACTIVE STATE LOGIC LEVELS.

Figure 27. DP8353 Video Character Signals



NOTE: DASHED LINES IN WAVEFORMS DENOTE INACTIVE STATE LOGIC LEVELS.

Figure 28. DP8353 Scan Line Signals

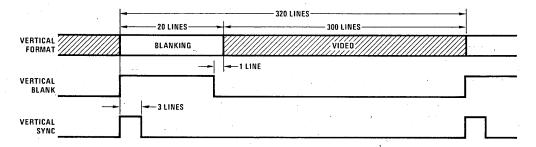


Figure 29. DP8353 60 Hz Refresh Rate Frame Signals

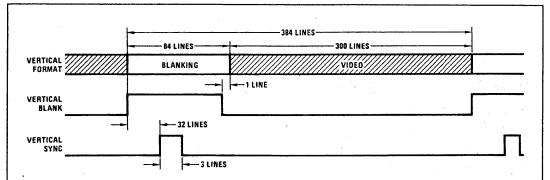


Figure 30. DP8353 50 Hz Refresh Rate Frame Signals

### A Low Component Count Video Data Terminal Using the DP8350 CRT Controller and the INS8080 CPU

INTRODUCTION

The DP8350 is an I<sup>2</sup>L — LS technology integrated circuit, designed to provide all control signals for a cathode ray tube (CRT) display system. This application note explains a system using the DP8350 and the INS8080 microprocessor. The design philosophy shows how the DP8350 interfaces to the INS8080, completing the function of a video data terminal with a minimum component count. After reading and understanding this application note the reader will realize the ease and flexibility of designing video terminals with the DP8350\*. To thoroughly understand this application note the reader must be familiar with the DP8350 and the INS8080 microprocessor.

The video data terminal described is divided into the following sections, (Figure 1).

The DP8350 CRT controller (CRTC).

The 8080 µP system which includes ROM, RAM, interrupt instruction port, oscillator, and control support chips.

The character generator.

The communication element,

The keyboard and baud rate select ports.

#### THE CRTC

The DP8350 generates all the required control and timing signals for displaying video information on the video monitor. Here is a summary of the controller's functions:

Dot clock, control, and counter outputs for the character generator.

Bidirectional RAM address refresh counter for refreshing the video RAM and allowing microprocessor loading to the internal DP8350 registers.

Direct drive horizontal and vertical sync signal outputs.

Direct cursor address location output. The cursor is internally delayed or pipelined, allowing for the access time of video RAM and the character generator ROM, (Figure 1).

#### THE CPU

The microprocessor provides CRTC, operator, and external machine control for the system. When the CRT controller is not actively refreshing the video RAM, (i.e., during vertical retrace or blank scan lines), the microprocessor is enabled for system housekeeping, (Figure 2). This method of multiplexing the RAM with \*The DP8350 is equivalent to the INS8276

National Semiconductor Application Note 199 Al Brilliott August 1978



the CPU and the CRTC eliminates the need for line buffers.

#### THE CHARACTER GENERATOR

The character generator consists of 3 elements: an address latch to hold the input address to the character ROM allowing for the access time of the ROM; the character ROM that stores the ASCII character in a form for parallel to serial conversion by the shift register; the shift register converts the character ROMs parallel output to serial form. The serial output from the shift register is the true video output, modulating the video monitors electron beam which writes characters on the screen. All of the 3 elements of the character generator are combined in the DM8678, (Figure 3). The DP8350 CRTC provides all the control signals for the DM8678.

#### THE COMMUNICATION ELEMENT

The INS8250 is the asynchronous communication element (ACE) for the data terminal. The ACE allows the CPU portion of the data terminal communication with peripherals or host computers at the correct baud rate, (Figure 1). The ACE is programmed by the CPU to send and receive serial data at the standard baud rates from 110 to 4800 baud. The ACE, in conjunction with the DS1488 and DS1489 line drivers and receivers, also provides full RS232C synchronous communication if higher baud rates are desired. System communication speed must always be considered to insure the baud rate does not exceed the time required for the CPU to process a data byte. Asynchronous communication at baud rates higher than 4800 are possible by adding a line buffer.

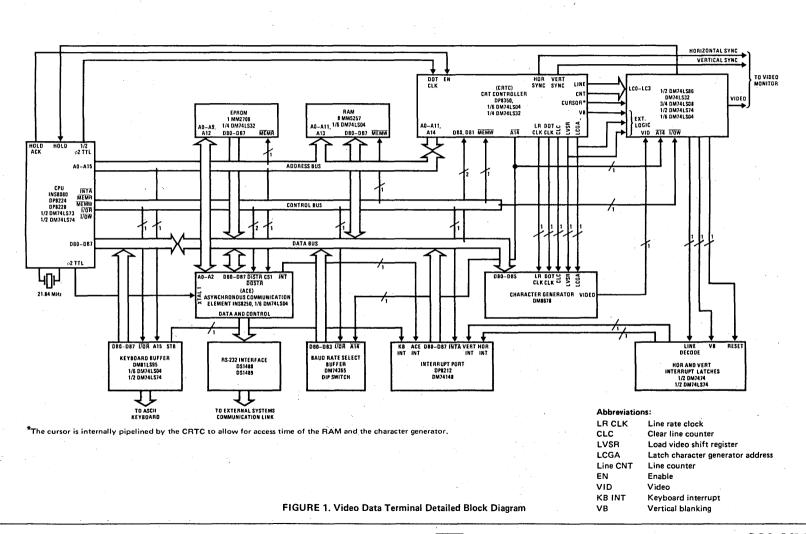
#### SYSTEM INITIALIZATION

Application of the terminal's power supply resets the microprocessor, the communication element, and the CRT controller. Resetting the ACE is necessary to clear the interrupt. Resetting the CRTC is not absolutely necessary since the microprocessor loads the cursor and top of page registers in the initialization routine.

Following the reset all interrupts are disabled to avoid unwanted interrupts from the CRTC, ACE, or I/O ports. Refer to the initialization routine in the flowchart.

The stack pointer is loaded to the bottom of scratch pad RAM (3FFFH) for use as the register save pointer, (Figure 4).

The entire RAM is written with ASCII spaces generating a cleared screen. After completion of the screen clear loop the CPU writes 000H to the cursor and the top of page registers in the DP8350 CRTC. The routine homes the cursor to the upper left corner of the screen. The top of page register was loaded with 000H, therefore, the video RAM is refreshed by the CRTC from that starting address to the last address on the screen of video RAM (1920 characters).



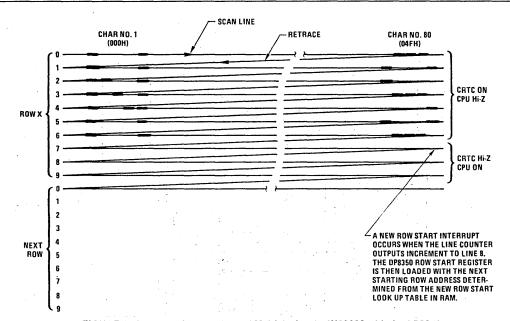


FIGURE 2. Row Start Interrupting and Multiplexing the INS8080 with the DP8350

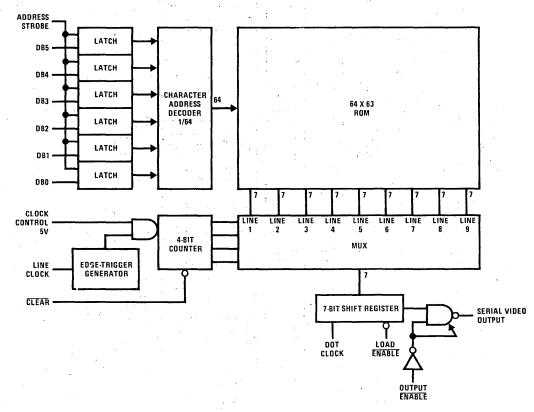


FIGURE 3. DM8678 Character Generator Block Diagram

The CPU is ready to perform the communication element (ACE) load routine. First, the baud rate divisor for the ACE must be determined. The baud rate select switch is read providing a code which corresponds to the appropriate 16-bit divisor for the ACE. This divisor determines the baud rate at which the ACE will communicate. Any additional programming requirements needed for the ACE to communicate with host computer systems could also be done at this time. The software in this system does not contain any additional programming for the ACE. There are many programming modes related to the ACE. Details of these modes are beyond the scope of this application note.

The row start look-up table, (Figure 5), is loaded up by a simple algorithm that loads and adds the data for referencing a row number to that row's starting address. The reference table, (Figure 6), is initialized next by direct loading. This table provides the CPU with top of page, bottom of page, next row load, cursor row, and scratch row numbers for system housekeeping.

Finally, the new row start and vertical interrupt latches are cleared, (Figure 7). The register pointers are loaded and the CPU is forced in a wait loop with interrupts enabled.

#### NON-SEQUENTIAL ADDRESSING

The data terminal described here was designed for non-sequential starting row addressing. In many systems sequential row addressing is used. If a character row consists of 10 scan lines the RAM is addressed 10 repetitive times from 000H through 04FH, (Figure 2). The next row is refreshed in the same manner from 050H to 09FH. The starting row address is sequential 000H, 050H, 0A0H—EB0H for row numbers 0H, 1H, 2H,—2FH, respectively. Non-sequential row addressing would be equivalent to 050H, 000H, 0A0H—EB0H for row numbers 1H, 0H,—2FH, respectively, (Figure 4).

In conjunction with the CPU, non-sequential row addressing is quite easily accomplished with the DP8350 since this is one of the features designed into the part. Accomplishing this task basically requires the following sequence of events. Assume the CRTC has finished writing a video row in the middle of the monitor's screen. This system has a 5 x 7 character font in a 7 x 10 field, (Figure 2). At the completion of the last video scan line 7 the CRTC line counters continue to count the last 3 lines. Video is not present since the character is only 7 scan lines high. The blank scan lines are 7, 8, and 9 permitting the CRTC address outputs to be TRI-STATED®, allowing the CPU to run. When the line counter outputs increment to scan line 8 an interrupt signals the CPU. The interrupt occurring is the new row start interrupt. The interrupt routine fetches the next CRTC row number from the reference table (Figure 6). This number is converted to the new starting row address, explained later, and loaded to the CRTC row start register. The CPU finishes the routine by clearing the interrupt, readying itself for the next new row start interrupt. The entire routine takes 1 scan line of time, approximately 64 \(\mu \)s. The CRTC continues to scan the video RAM from that new starting address on for the next 7 repetitive scan lines of the next row. Many advantages become apparent using the nonsequential addressing scheme. Scrolling up or down with the cursor always on the screen may be done

faster and easier from a hardware/software standpoint. Exchanging one row with another row is fast since it is not necessary to rewrite the video RAM. Row swapping is useful for higher end terminals requiring row editing functions.

#### ADDRESS MAP

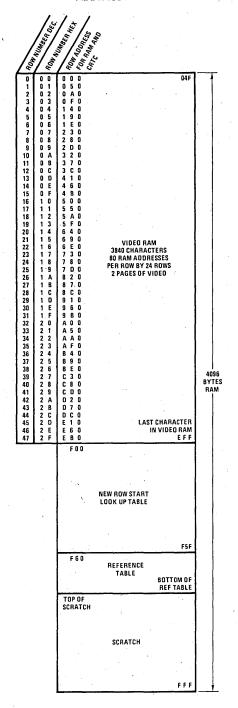


FIGURE 4. RAM Organization

#### **MEMORY REFERENCE TABLES**

Page 1

Page 2

raye i															
R	ROW				NRS HIGH				NRS LOW						
NUN			ADDRESS		ROW		ADDRESS				ROW				
DEC	HI	EX					DA	TA			_		DA	DATA	
0	0	0	3	F	0	0	3	0	3	F	3	0	0	0	
1	0	1	3	F	0	1	3	0	3	F	3	1	5	0	
2	0	2	3	F	0	2	3	0	3	F	3	2	Α	0	
3	0	3	3	F	0	3	3	0	3	F	3	3	F	0	
4	0	4	3	F	0	4	3	1	3	F,	3	4	4	0	
5	0	5	3	F	0	5	3	1	3	F	3	5	9	0	
6	0	6	3	F	0	6	3	1	3	F	3	6	E	0	
7	0	7	3	F	0	7	3	2	3	۰F	3	7	3	0	
8	0	8	3	F	0	8	3	2	3	F	3	8	8	0	
9	0	9	3	F	0	9	3	2	3	F	3	9	٠D	Ō	
10	0	Α	3	F	0	Α	3	3	3	F	3	Α	2	0	
11	0	В	3	F	0	В	3	3	3	F	3	В	7	0	
12	0	С	3	F	0	С	3	3	3	F	3	С	c	0	
13	0	D	3	F	0	D	3	4	3	F	3	D	1	0	
14	0	Ε	3	F	0	Ε	3	4	3	F	3	Ε	6	0	
15	0	F	3	F	0	F	3	4	3	F	3	F	В	0	
16	1	0	3	F	1	0	3	5	3	F	4	0	0	0	
17	1	1	3	F	1	1	3	5	3	F	4	1	5	0	
18	1	2	3	F	· 1	2	3	5	3	F	4	2	Α	0	
19	1	3	3	F	1	3	3	5	3	F	4,	3	F	0	
20	1	4	3	F	1	4	3	6	3	F	4	4	4	0	
21	1	5	3	É	1	5	3	6	3	F	4	5	9	Ó	
22	1	6	3	F	1	6	3	6	3	F	4	6	E	0	
23	1	7	3	F	1	7	3	7	3	F	4	7	3	0	

RO	ſ.	N	RS	ні	GH		NRS LOW							
NUN	NUMBER		ADDRESS		ROW		ADDRESS				ROW			
DEC	HE	ΞX	AL	-	16.	33	DA	TΑ	7.0		·-·	, ,	DATA	
24	1	8	3	F	1	8	3	7	3	F	4	8	8	0
25	.1	9	3	·F	1	9	3	7	3	F	4	9	D	0
26	1	Α	3	F	1	Α	3	8	3	F	.4	Α	2	0
27	1	В	3	F	1	В	3	8	3	F	4	В	7	0
28	1	С	3	F	1	С	3	8	3	F	4	С	С	0
29	1	D	3	F	1	D	3	9	3	F	4	D	1	0
30	1	Ε	3	F	1	Ε	3	9	3	·F	4	Ε	6	0
31	1	F	3	F	1	F	3	9	3	F	4	F	В	0
32	2	0	3	F	2	0	3	Α	3	F	5	0	0	0
33	2	1	3	F	2	1	3	Α	3	F	5	1	- 5	0
34	2	2	3	F	2	2	3	Α	3	F	5	2	Α	0
35	2	3	3	F	2	3	3	Α	3	F	5	3	F	0
36	2	4	3	F	2	4	3	В	3	F	5	4	.4	0
37	2	5	3	F	2	5	3	В	3	F	5	5	9	0
38	2	6	3	F	2	6	. 3	В	3	F	5	6	Е	0
39	2	7	3	F	2	7	3	С	3	F	5	7	-3	0
40	2	8	3	F	2	8	- 3	С	3	F	5	8	8	0
41	2	9	3	F	2	9	3	С	3	F	5	9	D	0
42	2	Α	3	F	2	Α	3	D,	3	F	5	À	2	0
43	2	В	3	F	2	В	3	D	3	F	5	В	7.	0
44	2	С	3	F	2	С	3	D	3	F	5	С	С	0
45	2	D	3	F	2	D	3	Ε	3	F	5	D	1	0
46	2	Е	3	F	2	Е	3	Ε	3	F	5	Ε	6	0
47	2	F	3	F	2	F	3	E	3	F	5	F	В	0

FIGURE 5. New Row Start Look Up Table

			*
FUNCTION	ADDRESS	DATA	INITIALIZED DATA
Last Row #	3F60	XY	17
8080 Row #	3F61	XY	00
First Row #	3F62	XY	00
Character #	3F63	XY	00
CRTC Row #	3F64	XY	00
Row Save #	3F65	XY	00
Temp. 1	3F66	XY	00
Temp. 2	3F67	XY :	00

IN	40	Read baud rate select switch
IN	80	Read keyboard
		interrupt latches
001	40	Clear new row start and vertical

**FUNCTION** 

FIGURE 7. Input/Output Space

FIGURE 6. Reference Table

DEVICE	ADDRESS*
ROM	0000 to 0FFF
RAM	3000 to 3FFF
CRTC	5000 to 5FFF
ACE	9000 to 9007

<sup>\*</sup>Direct device selecting was used to minimize the system component count

FIGURE 8. CPU Addressing Space

RO	OW	NRS HI	GH	NRS LOW			
NUN	1BER	ADDRESS	ROW	ADDRESS	ROW		
DEC	HEX	ADDRESS	DATA	ADDRESS	DATA		
32	2 0	3 F 2 0	3 A	-3 F∴5 O	0 0		
			. 1				

COMMAND

Row Start Address for Row 20H.

3XXX Selects RAM. 5XXX Selects CRTC.

FIGURE 9. Example From the New Row Start Look Up Table

Obtaining the next starting row address for the CRT controller is accomplished by an addressing and adding scheme from the new row start look-up table. The same scheme is used to determine any needed address, given the row number.

Figure 9 shows a row number and address taken from the new row start look-up table.

The row number is loaded from the reference table in RAM to a register. The CPU determines the starting address from the row number and stores it in a 16-bit pointer register. The higher order 4 bits contain address for the RAM or the CRT controller, (Figure 8).

Here are the details of how this is accomplished. Refer to the new row start interrupt in the software listing and Figure 9.

The CPU D-E registers are loaded to point to a row number in the reference table. The number is put in the accumulator and moved into the E register. The D-E register in this example now contains 3F20 which points to NRS HIGH ROW DATA (3A). The addressed data is moved to the accumulator and then to the H register. If it was desired to point to the CRTC then 20H would have been added to it first. The D-E register still contains 3F20H. To obtain the NRS LOW ROW DATA the E register is moved to the accumulator and 30H is added to it. Now the D-E register contains 3F50H and points to NRS LOW ROW DATA (00H). The data is loaded to the accumulator and then to the L register. The H-L registers contain 3A00H which is the starting row address for row number 20H. The method just described is used throughout the terminals program to move the cursor, load the top of page, and load the new starting row address in the CRTC.

#### VERTICAL INTERRUPT

The vertical interrupt occurs when the CRTC has completed refreshing a video page (1920 characters) of information. Vertical blanking identifies that condition and interrupts the CPU forcing it to the vertical interrupt routine. Refer to the vertical interrupt in the flow chart. The routine moves the first row number to the CRTC row number, updating it so the next new row start load occurs with the top of the page address or the first row of the video screen.

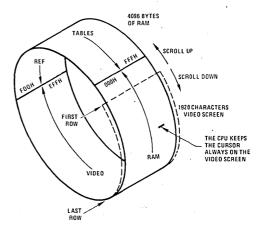
#### KEYBOARD INTERRUPT

The external keyboard requirements are ASCII outputs with a suitable strobe to interrupt the CPU for keyboard servicing. Refer to the keyboard interrupt in the flow chart. After the keyboard buffer is read the data byte is tested for a (CNTL E), new baud rate command. If the test fails the CPU writes the data byte to the ACE. Passing the test forces the CPU to read the baud switch and load the ACE with the new baud rate.

#### **ACE INTERRUPT**

As mentioned above, a data byte read from the keyboard that is not a baud rate command enters the accumulator. The CPU writes the data byte from the accumulator to the transmitter holding register in the ACE. The ACE proceeds to shift out the data byte, with the appropriate start and stop bits, serially from the (SOUT) output. The data is shifted to the serial input (SIN) of the ACE and loaded into the receiver holding register. When the register is full the ACE interrupts the CPU, initializating the ACE service routine. Refer to the ACE interrupt in the flow chart.

The CPU reads the receiver holding register in the ACE. Reading the ACE resets the interrupt. The data byte now resides in the accumulator. The CPU tests for a control or an escape function. The function is executed if test conditions are met. Refer to the keyboard interrupt routine in the software listing. The data byte is written to the video RAM at the cursor address which appears on the monitor screen. The cursor and character numbers are incremented as long as it is not at the end of a row. A character at the end of a row requires further testing to recognize the following situations. Is it the last row on the monitor's screen? Or is it on the maximum row of the video RAM? Essentially, the cursor is forced to stay visible on the video monitor's screen and video RAM is always kept out of scratch pad RAM, (Figure 10).

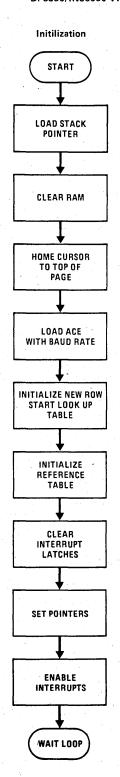


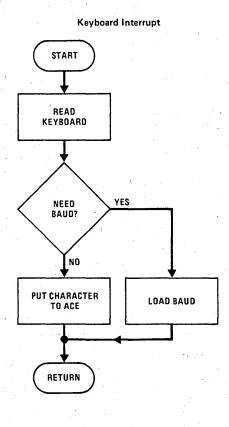
The video screen is allowed to scroll only through the video RAM (000H to EFFH). The CPU keeps the video screen within these bounds by loading the new row start register with that address range only (row 00H to 2FH).

FIGURE 10. Drum Analogy for the RAM

#### FULL/HALF DUPLEX OPERATION

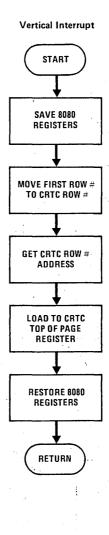
The data terminal and a host computer in the full duplex mode of operation would receive the serial information, process it, and send it back to the SIN input of ACE. Using the terminal in a stand-alone mode for testing, the serial out SOUT is tied to the serial in SIN of the ACE. In the half duplex mode a data byte is sent to the host computer at the same time it is sent to the terminal. When the data terminal is set up to communicate with a host computer the full duplex mode of operation is desirable.



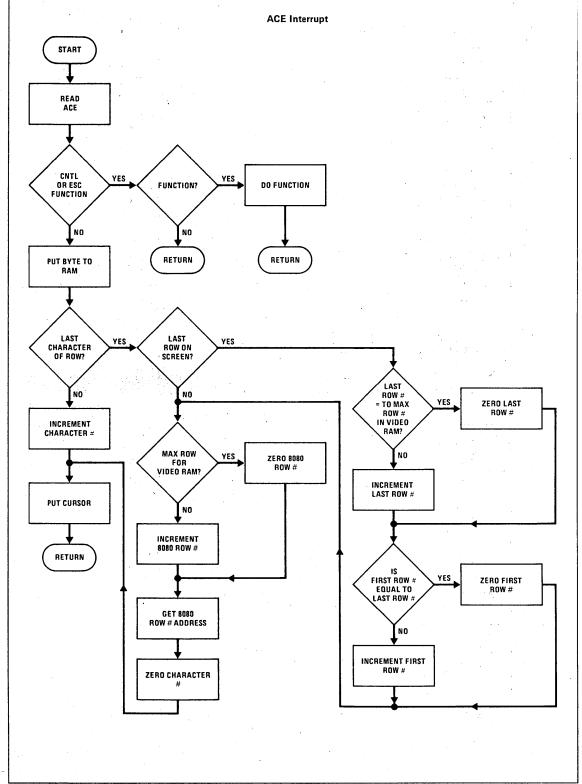


## **New Row Start Interrupt** START **SAVE 8080** REGISTERS LOAD CRTC ROW # TO CRTC RESET INTERRUPT LATCH MAX YES **ROW IN** ZERO CRTC VIDEO ROW # PAGE? NO **INCREMENT TO NEXT ROW #** SAVE THE ROW # **RESTORE 8080** REGISTERS ENABLE INTERRUPTS

RETURN



#### DP8350/INS8080 VIDEO DATA TERMINAL BASIC SOFTWARE FLOW CHART (Continued)



1			TITLE	CRTC - 8080A 02.	(15/78)	135 00E9 C31C01		JMP	ACELD	
3				MICONDUCTOR'S	VTROLLER BOARD **	136 00EC 117E00 137 00EF C31C01		JMP LXI	D. 0007E ACELD	1200 BAUD DIVISOR
5				JIM TROUTNER	THOUSEN BORNS **	139 00F2 115400 139 00F5 C31C01 140 00F8 114C00		JMP LXI	D, 00054 ACELD D, 0004C	, 1800 BAUD DIVISOR
7 8	0060		LASTRON		060	141 00FB C31C01 142 00FE 113F00		JMP LXI	ACELD D, 0003F	; 2400 BAUD DIVISOR
10	0061 0062		ROWSOSC FIRSTRO	) =	061 062	143 0101 C31C01 144 0104 112A00	B3600:	JMP LXI	ACELD D. 0002A	,3600 BAUD DIVISOR
11 12 13	0063 006 <b>4</b> 0065		CHARNUM CRTCROW ROWSAVE	1 =	063 064	145 0107 C31C01 146 010A 112000		JMP LXI	ACELD D,00020	.4800 BAUD DIVISOR
14	0065 0066 0067		TEMP1 TEMP2		065 066 067	147 010B C31C01 148 0110 111500		JMP LXI	ACELD D, 00015	,7200 BAUD DIVISOR
16	8300		IMASK:	=	068	149 0113 C31C01 150 0116 111000 151 0119 C31C01	E9600:	JMP LXI JMP	D. 00010 .	,9600 BAUD DIVISOR
13	0000 0000 F3	START:	=0000		DISABLE INTERRUPTS	152 153			DAD ROUTINE	
20	0001 31FF3F 0004 C33B00		LXI JMP	SP,03FFF INIT	LOAD STACK POINTER JUMP TO INITILIZE ROUTINE	154 155 0110 010390	ACELD:	LXI	B, 09003	POINT B C TO ACE
23	0007 0008 C32502		. =0008 JMP	NEWRO	NEW ROW START INTERRUPT	156 011F 3E83 157 0121 02		MVI STAX	A.083 B	; INIT BAUD LOAD - 8 BITS ; DO INIT BAUD LOAD
25	000B 0010 C34A01		.=0010 JMP	INTACE	ACE INTERUPT	158 0122 0E01 159 0124 7A		MVI	C. 001 A. D	; POINT TO BAUD HIGH ; GET BAUD HIGH
27	0018 C33901		=0018 JMP	INTER	*KEYBOARD INTERUPT	160 0125 02 161 0126 0E00		STAX MVI	C' 000 B	STORE BAUD HIGH TO ACE POINT ACE TO BAUD LOW
29	001B 0038 C34F02 003B 210030	TAUT T.	JMP LXI	VERT1 H, 03000	VERTICAL INTERUPT	162 0128 7B 163 0129 02		MOV STAX	A, E B	GET BAUD LOW STORE BAUD LOW TO ACE
31	003E 0E20 0040 3E3F	11411:	MVI MVI	C, 020 A, 03F	ASCII SPACE INTO C REG	164 012A 0E03 165 012C 79		MOV	C, 003	RESET DLAB TO ZERO INIT ACE T/R
33	0042 71 0043 23	CLRAM	MOV INX	M, Č H	ASCII SPACE INTO MEM	166 012D 02 167 012E 0E01		STAX MVI MOV	B C, 001	FUT TO ACE INTERRUPT ENABLE REG
35	0044 BC 0045 C24200		CMP JNZ	H CLRAM	:MAX RAM ADDRESS? :IF NO THEN NEXT ADD.	168 0130 79 169 0131 02 170 0132 0E00		STAX	A, C B . C, 000	SELECT RECEIVED DATA INTERR" LOAD IT RESTORE B-C ACE POINTER
37	0048 0E00 004A 3E40		MVI IVM	C, 000 A, 040		171 0134 D1 172 0135 C9		POP RET	D D	RESTORE D-E REGISTERS
40	004C 71 004D 23	CLRAM1:	INX .	M.C H		173 174			ARD INTERRUPT ROL	
42	004E BC 004F C24C00		OMP UNZ	H CLRAM1		175 176 0136 DB80	INTKB:	IN	080	; READ KEYBOARD
44 45	0052 CD8700 0055 CD9300		CALL	HMCUR BAUD	GO TO CUR HOME ROUTINE GO TO BAUD LOAD ROUTINE	177 0138 FB 178 0139 FE05		EI CPI	005	ENABLE INTERRUPTS NEED BAUD RATE? (CNTL E)
46 47			NEW RO	W START LOOK UP	TABLE GENERATION	179 013B CA9300 180 013E FE12		JZ CPI	BAUD 012 TUERTN	IF YES GO TO BAUD ROUTINE INVERT NEXT CNTL R
43	0058 21003F 005B 11303F		LXI	H, 03F00 D, 03F30	IN.R.S. HIGH ADDRESS IN.R.S. LOW ADDRESS	181 0140 CA4803 182 0143 FE13 183 0145 CA5403		JZ CPI JZ	013 IVERTR	; INVERT ROW CNTL S
50 51	005E 010030 0061 70	NRS:	LXI MOV	B, 03000 M, B	IN R.S. ADDRESS DATA	104 0149 02		STAX	B	STORE BYTE TO ACE
53	0062 79 0063 12		MOV STAX	A, C D	STORE TO N.R.S. DATA TABLE " N.R.S. DATA LOW TO ACC. STORE TO N.R.S. DATA TABLE L	186 187			NTERUPT ROUTINE	, AL LONG
55	0064 E650 0066 4F		ADI MOV	050 C. A	ACC READY FOR NEXT LOAD ACC TO N.R.S. DATA HIGH N.R.S. DATA TO ACC	188 189 014A 0A	INTACE:	LDAX	В	LOAD ACE DATA BYTE TO ACC.
57	0067 78 0068 CE00		MOV ACI	A, B .	AND CARRY BIT TO DATA HIGH MOVE RESULT TO N.R.S. DATA H	190 014B FB 191 014C FE7E		EI CPI	07E	ENABLE INTERRUPTS
59	006A 47 006B 2C		MOV INR	B. A L	INCREMENT N.R.S. HIGH ADD	193 0151 FE7F		JZ CPI	FUNC 07F	TEST FOR ESC COMAMD TEST FOR DEL COMAND
61	006C 1C 006D 7B		INR MOV CPI	E A, E	INCREMENT N.R.S. LOW ADD IN.R.S. ADD LOW TO ACC MAX TABLE ADDRESS	194 0153 CA7001 195 0156 5F 196 0157 E660		JZ MOV	FUNC E, A	SAVE CHAR IN REG. E
62 63 64	006E FE60 0070 C26100		JNZ	LASTROW NRS	IF FALSE JUMP	197 0159 CA7001		ANI JZ	060 FUNC	MASK OUT BITS FOR CNTL TEST IF ZERO JMP TO CNTL FUNC
65 66			REFERE	NCE TABLE INITI	.IZE	198 015C 3A683F 199 015F B3		DA ORA	03F68 E	LOAD INVERT MASK OR MASK AND CHAR
67	0073 3E17 0075 12		MVI STAX	A. 017 D	LAST ROW NUMBER TO ACC. STORE TO REFERENCE TABLE	200 0160 77 201 202		MOV	M. A CE CURSOR	STORE DATA BYTE TO RAM
69 70	00/3 12			FERIFHERAL INTE		202 203 204 0161 1E63	ADCUR:	MVI	E, CHARNUM	FOINT B-C TO CHAR #
71 72	0076 D340		OUT	040	IN. R. S. INTERRUPT CLEAR	205 0163 1A 206 0164 23	HDCOK.	LDAX	D H	LOAD CHAR # TO ACC.
74	00 <b>78 D</b> BS0		IN	080	KEYBOARD INTERRUPT CLEAR	207 0165 FE4F 208 0167 CABE01		CPI JZ	04F NXRO	LAST CHAR OF ROW? LE TRUE JUMP TO NEXT ROW
75 76				POINTERS	4	209 016A C601 210 016C 12		ADI STAX	001 D	; INCREMENT CHAR # ; STORE CHAR # TO RAM REF.
78	007A 11603F 007D 210030 0080 010090		LXI LXI	D, 03F60 H, 03000 B, 09000	/POINT D-E TO REFERENCE TABLE /POINT H-L TO 1ST RAM LOCATIO /POINT B-C TO ACE	212		JMP	PCUR	PUT CURSOR
80 81	0080 010070			.00P FOR INTERUP	*,	213 214 215 0170 78	FUNC	, TEST A	FOR FUNCTION	r a
82	0083 FB	BACK:	EI		ENABLE INTERRUPTS	216 0171 FE01 217 0173 CA0000	FUNC:	CPI .	A.E 001 START	HOME AND CLEAR CNTL A (SOH)
85	008 <b>4</b> C38300		JMP	BACK	LOOP UNTIL INTERRUPTED	218 0176 FEOD 219 0178 CA6E02		CPI JZ	OOD CR	CARRAGE RETURN
86 87				JP CURSOR		220 017B FE11 221 017D CA7B02		CPI JZ	011 SAVRO	SAVE ROW # CNTL Q (DC1)
89	0087 210050 008A 3E02	HMCUR:	MVI	H, 05000 A, 002	POINT B-C TO CRTC  TO P. REGISTER SELECT	222 0180 FEOC 223 0182 CA6101		CPI JZ	00C ADCUR	ADVANCE CURSOR CNTL L (FF)
91	008C 77 008D 3C 008E 77		MOV INR	M. A A M. A	T. O. P. LOAD CURSOR REGISTER SELECT	224 0185 FE02 225 0187 CAA402		CPI JZ	002 HOME	HOME UP CNTL B (STX)
93	008F 210030 0092 C9		MOV LXI RET	H, 03000	CURSOR LOADS TO T.O.P. POINT H-L TO 1ST RAM ADD: RETURN	226 018A FE1A 227 018C CAB502		CPI JZ CPI	O1A SWAP	SWAF CNTL Z (SUB)
95 96				RATE SELECT	/ ICTORIO	228 018F FE0A 229 0191 CA8D02 230 0194 FE08		JZ CPI	00A LF 008	; LINEFEED ; BACKSPACE CNTL H (BS)
97 98	0093 D5	BAUD:	PUSH	D	SAVE D-E REGISTERS	231 0196 CAE002 232 0199 FEOB		JZ CPI	BS .	UP CURSOR ENTL K (VT)
99 100	0094 DB40 - 0096 E60F		IN ANI	040 00F	READ BAUD SELECT CODE	233 019B CAF102 234 019E FE18		JZ CPI	UPCUR 018	CLEAR ROW CNTL X (CAN)
102	0098 FE00 009A CAD400		CP1 JZ	000 B110	:110 BAUD ROUTINE	235 01A0 CA3003 236 01A3 FE07		JZ CP1	CLROW 007	RING BELL CHTL G (BEL)
104	009D FE01 009F CADA00		CPI JZ	001 B150	150 BAUD ROUTINE	237 01A5 CA4503 238 01A8 FE12		CPI	BELL 012	INVERT NEXT CNTL R (DC2).
106	00A2 FE02 00A4 CAE000 00A7 FE03		CPI JZ CPI	002 B300	300 BAUD ROUTINE	239 01AA CA4803 240 01AD FE13		CPI	IVERTN 013	INVERT ROW CNTL S (DC3)
108	00A9 CAE600 00AC FE04		JZ CPI	003 B600 004	600 BAUD ROUTINE	241 01AF CA5403 242 01B2 C9 243		JZ RET	IVERTR	RETURN
110	00AE CAECOO 00B1 FE05		JZ CP I	B1200 005	:1200 BAUD ROUTINE	244 245		STORE	CURSOR TO CRTC F	ROM H-L REGISTERS
112	00B3 CAF200		JZ CPI	B1800 006	;1800 BAUD ROUTINE	246 01B3 7C - 247 01B4 C620	PCUR:	MOV ADI	A, H 020	H REG TO ACC. SET H-L REG TO CRTC ADD.
115	00BB CAF800 00BB FE07		JZ CPI	B2000 007	2000 BAUD ROUTINE	248 01B6 67 249 01B7 3603		MOV	H. A M. 003	H IS CRTC ADD. CURSOR REGISTER SELECT
117	00BD CAFEOO 00CO FEO8		OP I	B2400 008	2400 BAUD ROUTINE	250 0189 7C 251 01BA D620		MOV SUI	A, H 020	H REG SET BACK TO VIDIO RAM ADDRESS
119	00C2 CA0401 00C5 FE09		CPI	D3600 009	3600 BAUD ROUTINE	252 01BC 67 253 01BD C9		MOV RET	н. А	RETURN
121	00C7 CA0A01 00CA FE0A 00CC CA1001		JZ CPI JZ	B4800 00A B7200	4800 BAUD ROUTINE	254 255 256	•		out on occur.	
123	00CF FE0B 00D1 CA1601		CPI JZ	00B B9600	; 9600 BAUD ROUTINE	256 257 258 01BE CDDC01	NYPO:	CALL	NXRO1	GO TO NEXT ROW SUBROUTINE
125 126			•	RATE SET UP ROUT		259 01C1 CDF301 260 01C4 E5	CLROW3:	CALL	ZCHAR H	; ZERO CHARACTER ; SAVE H.L
127 128	00D4 116305	B110:	LXI .	D, 00563	; 110 BAUD DIVISOR	261 01C5 1E60 262 01C7 1A		MVI	E, LASTROW D	POINT D.E TO LASTROW
129 130	00D7 C31C01 00DA 11F303	B150:	JMP ·	ACELD D, 003F3	GO TO ACE LOAD ROUTINE 150 BAUD DIVISOR	263 01C8 C601 264 01CA FE30		ADI CPI	001 030	POINT AC TO FIRST ROW OFF SC
132	00DD C31C01	B300:	JMP LXI	ACELD D, 001F9	300 BAUD DIVISOR	265 01CC CAD701		JZ	ROZERO	
133	00E3 C31C01 00E6 11FC00	B600:	JMP LXI	ACELD D, 000FC	, 600 BAUD DIVISOR	Continued on p	age 5-4	2		
						20				

#### **FEATURES**

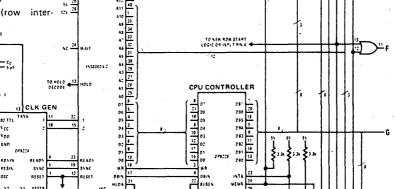
- Keyboard input port
- Serial I/O up to 9600 baud 4k bytes RAM 1k byte ROM
- 2 video pages
- 80 x 24 characters
- 5x7 character font, 7x10 field size
- Block cursor
- Single crystal
- Maximum CPU time/frame without line buffers
- Line or page scroll capability
- Full cursor control
- Complete software flexibility
- Modem control capability
- Low component count

LC FOR OVERTONE MODE ONLY

- Field reverse
- Clear screen, clear row, home and clear

VEC

Row swap (row interchange)



VEVW 174

CRTC ADDRESS

PROM

37

15 15

120

PORT

PATA: (13 "3 34 PULL UPS DISTR ATEGA INTRET TO RESET PIR 12 8898 WR DISTR 103

3 T 41 141:00:00

254 AT 272

DOT:

00T 2

4130

h3A

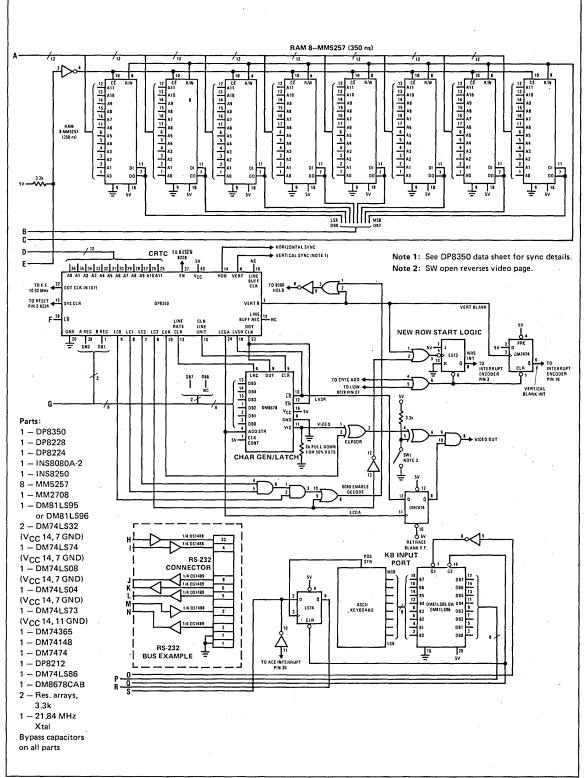
CS1

DATA 7 DATA?

....

PATA 3

3 DATAS



266 01CF CD8302 LOOPS	CALL LOHL1	LOAD H.L WITH ADD OF LASTRO			, CARPAGE	PETUPN	
267 01D2 CD3B03 268 01D5 E1 269 01D6 C9 270	CALL CLROW2 POP H RET	. RESTORE H.L	401 402 026E 1E63 403 0270 3E00 404 0272 12	CF	MVI i	E. CHARNUM A. 000 D	.POINT D-E TO CHAP #
271 01D7 3E00 ROZERO . 272 01D9 C3CF01	MVI A.666 UMP LOOPS	LOAD ROW ZERO	405 0273 1E61 406 0275 CD8202 407 0278 C3B301		MVI CALL	E. POW8080 LDHL PCUP	CUPSOR TO THE BEGINNING OF R
273 274 275	, NEXT FOH		408 409		, SAVE POI		COPSOR TO THE BEGINNING OF R
276 01DC 1E60 NXR01 277 01DE 1A 278 01DF EB	MVI E, LASTROW LDAX D XCHG	.POINT D-E REG TO LAST ROW .PUT LAST ROW # TO ACC .EXCHANGE H-L WITH D-E	410 411 027B 1E61 412 027D 1A	SAVPO	LDAY	E. POW8080 D	.POINT D-E TO SOSO POWW .PUT SOSO POW W TO ACC
279 01E0 23 280 01E1 BE 281 01E2 CA0502	INX H CMPM .JZ SCROLL	.H-L IS NOW AT 8080 FOR HILW W WOR TEAL STANDO LOOS FULL IF THE SCROLL	413 027E 1E65 414 0280 12 415 0281 C9			E. ROWSAVE D	.POINT D-E TO POW SAVE .STORE ROW SAVE # IN REF TAB' .RETURN
262 283	, INCREMENT 8080 POW #	10000 Film W IT THOSE SCHOOLS	416 417			DATA LOAD POUTI	
284 285 0165 362F INCRO 286 0167 BF	MVI 4, 62F CMP M	. TEST FOR MAY ROW AND . JUMP TO ZEPO POW IF TRUE	418 419 0282 1A 420 0283 5F	L DHL L DHL 1	MOV	D E. 4	LOAD ACC WITH D-E DATA POINT D-E TO N P S DATA HI
287 GIES CAFBGI 288 GIEB 34 289 GIEC EB	J7 ZROW INP M XCHG	. ZERO POW . INCREMENT THE SOSO ROW # . POINT H-L TO CHAR #	421 0284 1A 422 0285 67 423 0286 7B		MOV	D H. A A. E	POW N TO N P S DATA, HIGH POW N TO H PEG PUT IST POW N TO ACC ACC TO N P S ADD LOW
290 01ED 1E61 291 01EF CD8202 292 01E2 C9	MVI E.ROWBOBO CALL LDHI RET	, PETUPN	424 0287 C630 425 0289 5F 426 0284 1A		MOV I	030 E. A D	.ACC TO N P S ADD LOW .POINT D-E TO N P S DATA LOW .POW # TO N P S DATA LOW
293 294 295	ZERO CHARACTER		427 0288 6F 428 028C C9 429			Ľ, A	. POW # TO L REG . RETUPN
295 296 01F3 3E00 ZCHAR 297 01F5 32633F	MVI : A, 666 STA 63F63	. PUT CHAP # TO ZEPO . AND STOPE	430 431		, LINEFEE	D	
298 01F8 C3B301 299 300	JMP PCUR .ZERO 8080 POW #	GO TO PUT CUPSOR POUTINE	432 028D CDDC01 433 0290 CDC401 434 0293 1E61	LF	CALL	NXRO1 CLROW3 E. POW8080	.DO NEXT POW SUBPOUTINE .OFF SCREEN CLEAP ROW ROUTINE .MOVE REFERENCE POW # TO H-L
301 302 01FB 3600 ZPOW	MVI M, 000	.8080 POW # TO ZEPO	435 0295 CD8202 436 0298 34633F	ADDCH	CALL I	LDHL 03F63	.LOAD H-L .CHAP # TO ACC
303 01FD 2E00 304 01FF 56 305 0200 2E30	MVI L,000 MVI L,030	.N P S ADDRESS HIGH .N P S DATA HIGH TO D PEG .N R S ADDRESS LOW	437 0298 85 438 029C 6F 439 029D 7C		MOV	L L, A A, H	.ADD THE CHAP # TO THE .FIPST POW ADDRESS .IF A CAPRY OCCUPED ADD TO
306 0202 SE 307 0203 EB	MOV E, M XCHG	.N P S DATA LOW TO E PEG .EXCHANGE H-L WITH D-E	440 029E CE00 441 02A0 67		MOV	000 н. 4	THE DATA HIGH H-L POINTS TO LINE FED FOW
308 0204 C9 309 310	RET , ROW SCROLL	PETUPN	442 0241 C3B301 443 444			PCUP PSOP TO T O P	.PUT CUPSOR TO LINE FED POW
311 312 0205 2B SCPOLL 313 0206 3E2F	DCX H MVI A, G2F	.POINT H-L TO LAST ROWN .BEFORE SCRATCH TABLES	445 446 02A4 1E62 447 02A6 1A	HOME	нуі	E.FIPSTPO	,POINT D-E TO 1ST POW ,STORE FIRSTPOW TO POWSOSO
314 0208 BE 315 0209 CA1902	CMP M JZ ZLRO	. TEST FOR THE LAST POW . JUMP TO ZEPO LAST POW IF TP	448 02A7 1E61 -		MVI STA/	E. POWRORO D	
316 0200 34 317 318	INP M	INCREMENT TO NEXT FOW	450 02AA CD8302 451 02AD 3E00 452 02AF 32633F		MVI STA	LDHL1 4,000 03F63	,MOVE REFERENCE ROW TO H-L .PUT CHAR # BACK .TO ZERO
319 320 020D 2E62 ROLO 321 020F BE	MVI L.FIRSTRO	.POINT H-L TO FIRST POWN .IS FIRST LOW = TO LAST POW	453 0282 038301 454 455		JMP ,SWAP PO	PCUP WS	. PUT CURSOP HOME
322 0210 CA1E02 323 0213 34	JZ ZFPO INR M	JUMP TO ZEPO FIRST P INCREMENT TO NEXT POW	456 457 0285 1E65	SWAP	MVI	E. POWSAVE	POINT D-E TO POW SAVE # AND
324 0214 2E61 325 0216 C3E501 326	MYI L. POWSOSO JMP INCPO	, POINT H-L TO SOSO POW , GO TO INCREMENT ROW POUTINE	458 0287 CD8202 459 0284 22663F 460 028D 1E61		SHLD .	LDHL OBFAA E. POWBOBO	.PUT IN H-L PEG .STORE POW SAVE # TO TEMP 1 * .POINT D-E TO SOSO POW # AND
327 328 329 0219 3600 ZLPO	MVI M. 000	.PUT LAST POW# TO ZEPO	461 02BF CD8202 462 02C2 1E65 463 02C4 1A		MA1	LDHL E. POWSAVE D	. PUT ADDRESS IN H-L REG . POINT D-E TO POW SAVE # AND . PUT IN ACC
330 021B C30D02 331	JMP ROLO	. SO TO POUTINE FOR FIRST POW	464 02C5 5F 465 02C6 7C		MOV MOV	E. 4 4. H	.2080 POW # TO ADD HIGH .3TOPE 8080 POW # TO N P S
332 333 021E 3600 ZFR0 334 0220 2E61	MVI M. 000 MVI L. POW8080	, PUT FIRST ROW# TO ZEPO , POINT H-L TO 8080 POW	466 02C7 12 467 02C8 7B 468 02C9 C630		MOV	D 4. E 939	.5474 PIGH
335 0222 C3E501 336 337	JMP INCRO	GO TO INCREMENT FOW POUTINE	469 02CB 5F 470 02CC 7D 471 02CD 12		MOV	E. 4 4, L D	PUT 8080 POW # TO ,N P S DATA LOW .8080 POW # IS NOW IN POW SA
338 339 0225 F5 NEWRO 340 0226 E5	PUSH PSW PUSH H	.SAVE ACC AND FLAGS .SAVE H-L PEG	472 02CE 24663F 473 02D1 1E61 474 02D3 1A		HVI HVI	ÖSF66 E. POW8080 D	. PUT POH SAVE # BACK TO H-L . COMENT SAME AS ABOVE
341 0227 D5 342 0228 11643F	PUSH D LXI D.03F64.	POINT DEE TO CRICPOW #	475 0204 SF 476 0205 70		MOV MOV	E, 6 6, 4	
343 022B 1A 344 022C 5F 345 022D 1A	HOV E.A	.LOAD ACC WITH-CPTC POW # .N P S DATA ACC HIGH TO E .POW DATA HIGH INTO ACC	477 02D4 12 478 02D7 7B 479 02D8 0630		MOV .	D 4. E 030	
346 022E 0620 347 0230 67 348 0231 7B	ADI 020 MOV H. A MOV A. E	N F S DATA ADD HIGH INTO H	490 02DA 5F 481 02DB 7D 1		MOV	E. 4 4. L D	
349 0232 C630 350 0234 5F	ADI 030 MOV E.A	. ACC 'TO N R S DATA LOW . N R S DATA ADD LOW TO E REC	483 02DD 039802 3 484		JME	ADDCH .	. JUMP TO 455 CHAP
351 0235 1A 352 0236 6F 353 0237 3601	LDAY D MOV L.A MVI M.OO1 .	.POW DATA LOW TO ACC .N P S DATA ADD LOW INTO L .STOPE N P S . TO CPTC	485 . 486 487 02E0 1E63	BS		ACE E. CHAPNUM	. POINT THE D-E REG TO CHAR *
354 0239 D340 355 023B 1E64 356 023D 1A	OUT 040 MVI E.CRTCROW LDAY D	PESET N P S AND VERT INTER	488 02E2 1A 489 02E2 FE00 490 02E5 CAEE02		CF I	D GGG UPPOW	.AND FUT IN AGG .TEST FOR THE CHAR # =. .TO ZERGUMF IR TRUE
357 023E FE2F 358 0240 CA4A02	CPI O2F JZ ZCPTC	.TEST FOR CPTC MA/ POW .IF TRUE ZEPO ACC	491 02E8 3D 492 02E9 12		DCP STA/	5	.DESPEMENT SHAP #
359 0243 30 360 0244 12 L00P 361 0245 D1	INP A STAX D POP D	.INCPEMENT TO NEXT POW .STORE NEXT POW NUMBER	493 02EA 2B 494 02EB 03E301 495		DME DC1	PCUP	DEC HEL FOR NEW CURSOR LOCA PUT SURSOR IN DECREMENTED LO
362 0246 E1 363 0247 F1 364 0248 FB	POP H POP FSW EI	. PESTORE H-L FEG . PESTORE ACC AND FLAGS	496 497 498 G2EE 3E4F	UPPOH		W UE: 6,04F	HOVE THE CHARLS
365 0249 C9 366	PET .	PETURN	499 02F0 12 500	O-7-5#	574/	Σ΄,	TO SOH AND STOPE IT.
367 368 369	ZEPO CRTCPOW	:	501 502 503 02F1 EB	UPCUP	, MOVE IS. XSHG		.FIINT HEL TO 8080 FOW AND DECTO NEW CURSOF LOCATION
370 024A 3E00 ZCRTC 371 024C C34402 372	MVI A.000 - JMP LOOP	.ZEPO ACC	504 02F2 2E61 505 02F4 7E 506 02F5 23		MGV	L. FÓWEGEG A. M H	TO NEW CURSOR LOCATION TEST IR NEWT UP CURSOR WILL BE ON THE FIRST FOW LIF TRUE JUMP TO
373 374 375 024F F5 VERTI	VERTICAL INTERPURT	SAVE ACC AND FLAGS	507 02F4 BE 508 02F7 0A0803		CMF .Z	M SPSCL	JE SOFOLL FOUTINE
376 0250 E5 377 0251 D5	PUSH H PUSH D	SAVE H PEG	509 02FA 25 510 511 02FB FE00	BACK1	CPI	906	.POINT HEL BACK TO SOSO FOR #
378 0252 1E62 379 0254 1A 380 0255 1E64	MVI E,FIRSTRO LDAX D MVI E,CRICROW	.POINT D-E TO FIFST FOW # .LOAD 1ST POW # INTO ACC .POINT D-E TO CPTCPOW #	512 02FD 041E03 513 0300 35 514		JZ	E049 M	.IF 8080 POW # 18 EDUAL TO .ZEFO JUMP TO ROW 48 POUTINE .DESPEMENT 8080 POW #
381 0257 12 382 0258 E63F 383 025A 5F	STAX D ANI O3F MOV E.A	.UPDATE CRTCROW # .FEMOVE MARKEF .POINT H L TO CRTC FIRST ROW	515 0301 EB 516 0302 CD8202	LOCF:	XCHG S <u>EL</u> L	LD4L	FOINT HHL TO NEW CUPSOF LOCA AND CHE TO SOBO FOW # JUME TO ADD CHAPACTER FOUTINE
384 0258 1A 385 0250 C620	LDAX D ADI 020	TO SEED IN SETS FIRST FOW	518 519 0309 7E	UPSCL	MOV	4000H A. M.	
386 025E 67 387 025F 7B 388 0260 0630	MOV H, A MOV A, E ADI 636		520 0309 FE00 - 521 030B CA2403 522 030E 35		0FI	000 FP049 M	FUT FIRST FOW # INTO 400 TEST IF FIRST FOW # IS # TO ZERO IF TRUE JUMP TO POW 48 FOUTINE
389 0262 5F 390 0263 1A 391 0264 6F	MOV E.A LBAX D MOV L.A		523 524 030F 2EA0	LIDEZ		L. LASTPON A. M	· · · · · · · · · · · · · · · · · · ·
392 0265 3602 393 0267 D340	MVI M. 002 OUT 040	STORE TOP OF PAGE	525 0311 7E 526 0312 FE00 527 0314 CA2A03	3 -	C# 1	6. M 000 LP048	
394 0269 D1 395 026A E1 396 026B F1	POP D POP H POP PSW	PESTORE ACC AND FLAGS	528 0317 35 529 530 0318 2E61	LOCES	BSF /	M L. FOWEGEG	. POINT H-U TO BOBS FROW ■
397 026C FB 398 026D C9 399	EI RET	PETURN	531 031A 7E 532 031B 03FB01 533		MOV	6. M B45F1	ANE 1940 TO 400
L							

ı													
	534	031E	3E2F	R048:	MVI	A, 02F	CHANGE 8080 ROW #	A	0007	ACELD	0110	ADCUR	٥
l		0320					CHANGE SOSO ROW # ;TO 23D AND STORE ;JUMP TO POINTER EXCHANGE ROU	В	0000	B110	00D4	B1200	
l	536	0321	C30103		JMP	LOOP1	JUMP TO POINTER EXCHANGE ROU	B1600	00F2	B2000	00F8	B2400	0
ŀ	537							B3600	0104	B4800	010A		O.
ı		0324		FR048:		A, 02F		B9600	0116	BACK	0083	BACK1	
١.			77			M, A		BAUD	0093	BELL CLRAM	0345	BS.	0
l		0327	C30F03		JMP	LOOP2		CHARNU	0093	CLRAM	0042	CLRAM1	
ı	541							CLROW1		CLROW2	033B 0002	CLROW3 DONE	
ı	542	03ZA	3E2F	LR048:	MUA	A, 02F M, A	PUT THE 1ST ROW TO	CRTCRO FIRSTR	0064	D FRO48			ŏ
		032C	77 C31803		JMP	M. A LOOP3		HMCUR		HOME		IMASK	
١	545	0320	C31803		UNIF	LUUF3	SOUND TO SOUD ROW # STURE	INIT		INTACE		INTKB	
ı	546				CLEAR I	ROW ROUTINE		IVERTR	0354	IMINCE	0005	LASTRO	
ı	547				, CLEMR I	NOW KOUTTNE		LDHL1	0283	L LF	028D	LOOP	
!		0320	CD2403	CLROW:	CALL	CLROW1		LOOP2	030F	LOOP3	0318	LOOP4	
					JMP	CR		LOOP6	035C	LR048	032A	м	0
ì	550	0000				•		NRS	0061	NXRO	OIBE	NXR01	
ı	551	0336	1E61	CLROW1:	MVI	E, R0W3080		PS₩	0006	RESET	0352	RESET1	
ı						LDHL	;PUT ROW DATA IN H-L REG ;INTILIZE LOOP COUNTER. ;STORE ASCII SPACE IN MEM. ;DECREMENT LOOP COUNTER. ;RETURN IF ZERO BIT IS SET.	ROLO	020D	ROW808	0061	ROWSAV	
ı	553	033B	3E50	CLROW2:	MVI	LDHL A, 050 M, 020 A	;INTILIZE LOOP COUNTER. ;STORE ASCII SPACE IN MEM. ;DECREMENT LOOP COUNTER. ;RETURN IF ZERO BIT IS SET. ;NEXT LOCATION	SAVRO	027B	SCROLL	0205	SP	
ı	554	033D	3620	LOOP4:	MVI	M, 020	STORE ASCII SPACE IN MEM.	SWAP	02B5	TEMP1	0066 *	TEMP2	0
1	555	033F	3D		DCR	A	DECREMENT LOOP COUNTER.	UPROW	02EE	UPSCL	0308	VERTI	
ı			cs .		RZ	н	RETURN IF ZERO BIT IS SET.	ZCRTC	024A	ZFRO	021E	ZLRO	0
Į.		0341	23	LOOP4:	INX	п	, NEXT LUCHTION						
		0342	C33D03		JMP	LOOP4	CLEAR NEXT LOCATION.	NO ERI	CHECKSUM				
l	559			BELL:		001	AING BELL		CHECKSUM				
ı			C9		RET	001	FRING BELL		FILE 1		SPC ON I	TMEM	
ı	562		٠,		NE I				FILE I				
ŀ	E/ 2	0240	AF	IVERTN:	XRA	A		00000			2 0 01.		
ł	564	0349	1E68		MVI		POINT D.E TO MASK						
	565	034B	1A		LDAX	D							
ı	566	034C	17		RAL		CK BIT 8 STATUS						
ı	567	034D	DA5203		JC	RESET							
	568	0350	3E80		MVI	A. 080	; INVERT BIT 8 ; STORE OUT NEW MASK						
	307	0.332	14	RESET:	SIMA	D	STORE OUT NEW MASK						
1			C9		RET								
ı	571												
ı		0354		IVERTR:		н :							
ı	573	0355	1E61		MVI	E, ROWSOSO	1010 407 400 00 00000001 70						
1	5/4	0357	CD8202 1E50		CALL	LUHL	LOAD 1ST ADD. OF 8080ROW TO						
1		0350		LOOP6:	MUN LIAT	A M	SET COUNTER GET CHAR						
1				LOOF 6.	RAI	E, OSO A, M	CK BIT 8 STATUS AND INVERT						
ı	578	035E	DA7003		JC	RESET1	TOK DATE OF OTHER PROPERTY.						
ı	579	0361	1F		RAR								
I	580	0362	17 DA7003 1F F680		ORI		; MASK BIT 8 HIGH						
ì	501	0.344	77	DACK 2	MOV	M, A	STORE MOD. CHAR TO MEM						
ı	582	0365	23		INX		POINT TO NEXT MEM						
ı	583	0366	7B		MOV	A, E							
	584	0367	FEOI	DHCK2.	CPI	001							
ı	585	0369	CA7603		JZ		RETURN IF COUNT = ZERO						
ı	586	0360	10		DCR		DEC. COUNTER						
ı	588	0360	C35C03		JMP	L00P6							
ı		0370	15	RESET1:	DAD								
1			E67F		ANI	07F	RESET BIT 8						
l			C36403		JMP	BACK2	ANGUEL BAT O						
ı	592		230403		O. IF	Driche .							
ı		0376	E1	DONE:	POP	н .							
ı		0377	C9		RET						٠.,		
	595		0000		END	START							
ı													

#### **DEFINITIONS**

CRTC — Cathode ray tube controller
Video Page — Visible screen data
Video RAM — Entire portion of RAM used only
for display
First Row # — Address for top row of video page
Last Row # — Address for bottom row of video page
CRTC Row # — Address for next row load
8080 Row # — Address for cursor row
Character # — Character location in a row
XXXH are hexidecimal numbers

ACE - Asynchronous communication element

#### REFERENCES

#### National Semiconductor Data Sheets:

DP8350 Series Programmable CRT Controllers INS8250 Asynchronous Communications Element DM8678 Bipolar Character Generator INS8080 Assembly and Reference Manuals

#### National Semiconductor Application Notes:

Simplify CRT Terminal Design with the DP8350, AN-198

DM8678 Bipolar Character Generator, AN-167

Data Bus and Differential Line Drivers and Receivers, AN-83

Transmission Line Characteristics, AN-108

Hardware Reference Manual BLC 80/10 Board Level Computer. National Semiconductor Microcomputer Systems Chapter 6 — System Interfacing.

# **Graphics Using the DP8350 Series of CRT Controllers**

National Semiconductor Application Note 212 Charles Carinalli December 1978



The DP8350 CRT Controller series is a versatile building block for both low and high-end CRT terminal applications. This application note demonstrates how the DP8350 may be used in CRT graphics applications. Although this presentation is general, when specific examples are given the DP8350 ROM programmed version of the DP8350 series will be used (80 characters per row, 24 character rows, 5 x 7 character, 7 x 10 character field size).

BACKGROUND INFORMATION

The basic function of the DP8350 CRT controller is to control the elements of the "video loop" (Figure 1). A memory address generated by the CRT controller is presented to the CRT memory, which stores a record of what appears on the CRT display. The character generator converts this stored information into serial video data to the CRT monitor. The intensity of the CRT electron beam is modulated by this video data and its position is controlled by the horizontal and vertical sync pulses generated by the CRT controller.

The CRT screen video area is divided into character cells (Figure 2). Each cell has a unique CRT memory address. The DP8350 must present the correct character cell address to the CRT memory at the appropriate CRT beam location. Use of the line counter outputs of the DP8350 make possible the subdivision of each character cell address into the unique scan line of the present CRT beam location.

For the DP8350 and its unique internal ROM program format, each character cell is composed of 70 dots (7 dots wide and 10 dots high) Figure 3. When using the DP8350, each of these dots may be active video data. Typically however, in alphanumeric display systems, the character generator will provide cell to cell character spacing on the CRT screen by blanking some number of rows and columns of dots. That is why the DP8350's  $7 \times 10$  dot field is used with a  $5 \times 7$  character generator (2 horizontal and 3 vertical dot spaces).

In fact, it is the character generator that restricts the use of the full character cell dot field, not the DP8350! Using a character generator which allows video on every scan line and all dots of the cell width, makes graphic capability possible. This type of graphic display generation is called "character generator graphics."

All of the dots on the CRT display may also be independently controlled by a separate CRT memory address location; this is called "memory mapped graphics."

Both of these graphics display generation techniques will be discussed here, with demonstrations of how the DP8350 series may be used to reduce total component count.

#### CHARACTER GENERATOR GRAPHICS

In this graphics system (Figure 4) the character generator block contains a ROM that has been programmed with graphic symbols whose size is contained within the character cell size. This ROM may at the same time contain alphanumeric characters that do not use the full character cell size.

The block representation and operation of this system is the same as the alphanumeric's system previously described. The CRT memory presents the same character cell data to the character generator on every scan line of that character cell address. The character generator ROM is organized with addresses defining a particular symbol and addresses defining which scan line of a character row the CRT electron beam is currently on; thus defining the video data for that scan line of the symbol. The scan line address data comes directly from the DP8350. The parallel data that results is video data for that screen address cell width. This data is then serially shifted to the CRT monitor with a parallel to serial shift register.

This system allows every scan line of a character row to have active video information, thus the graphics symbol may be programmed to all sides of the character cell providing continuity from cell to cell both horizontally and vertically. At the same time, the alphanumeric's character may be programmed with cell to cell spacing.

Character generator graphics is the simplest most costeffective approach to CRT graphics. It requires a minimum of software development and hardware support. The DP8350 CRT controller provides all the required timing and control pulses for the CRT memory, character generator, and CRT monitor.

Graphics capability with this system, however, is somewhat limited since individual dot control is not possible; only character cell symbol control is available. This system does apply well in such applications as bar graphs, circuit schematics, or flow charts and when these need to be combined with alphanumeric data.

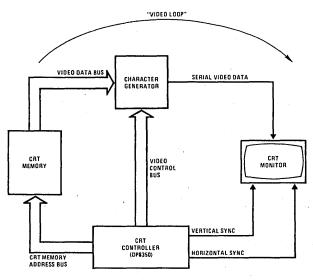


FIGURE 1. Elements of the "Video Loop"

			C	HARACI	TER CELLS	S PER R	)₩				
0	١,	2	3	4	••••	75	76	77	78	79	ROW
80	. 81	82	83	84		155	156	157	158	159	ROW 2
160	161	162	163	164	••••	235	236	237	238	239	ROW
240	241	242	243	244	••••	315	316	317	318	319	ROW 4
:	:	:	:	:	-	:	:	:	:		
:	:	:	:	:		:	:	:	:	:	
1680	1681	1682	1683	1684	••••	1755	1756	1757	1758	1759	ROW
1760	1761	1762	1763	1764	••••	1835	1836	1837	1838	1839	ROW
1840	1841	1842	1843	1844	1	1915	1916	1917	1918	1919	ROW 2

FIGURE 2. CRT Screen Cell Address Map Presented to CRT Memory by the DP8350 (Top of Page Register Contains Address 0) Character Cells Per Row = 80 Character Rows Per Frame = 24

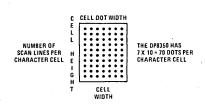


FIGURE 3. The DP8350 Character Cell is 7 Dots Wide and 10 Dots High

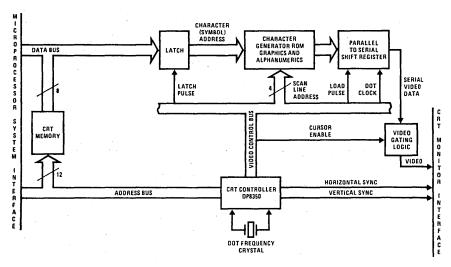


FIGURE 4. Character Generator Graphics

## CHARACTER GENERATOR GRAPHICS—WITH LINE BUFFERS

Modification of the character generator graphics block diagram is possible with the addition of a recirculating line buffer placed between the CRT memory and the character generator (Figure 5). In this case the character generator addresses for a character row are loaded serially into this shift register on the scan line before the first video scan line of a character row. These addresses are then recirculated for the number of scan lines per character row minus one (then the next character row of addresses is loaded). This system allows access to the CRT memory by the system controller on all but one scan line of a video character row. In contrast, the system previously described would have allowed access only during blanking intervals. In systems that require heavy access to the CRT memory to update screen information, this approach is very attractive.

In this case, as before, all the required control pulses for the "video loop" are provided by the DP8350 CRT controller.

#### MEMORY MAPPED GRAPHICS

If a very high resolution graphics display is required, every dot of the CRT display may be independently controlled. In this case, every dot of the CRT screen may be mapped to a specific CRT memory data bit—thus the name Memory Mapped Graphics. This type of system is obviously a more costly type of graphics, since to control every dot not only is there a need for more CRT memory, but the microprocessor overhead in such

a system will be greater—both software and hardware. In any case, the DP8350 easily adapts to such a system as demonstrated in *Figure 6*.

In this approach, if you subdivide each character cell such that each scan line of the cell may be independently addressed, then from the CRT memory block instead of 8 bits of data defining a character cell code to the character generator, you get 8 bits of direct video data. Then the CRT memory block serves double duty—CRT memory storage and symbol or character generator. All that is left to do is convert this parallel video data to serial video data as before.

In the case of the DP8350 internal ROM format program, each cell is 7 dots wide; thus only 7 bits of video data are needed per character cell/scan line address. The DP8350 addresses the memory block as before with the character cell address, but in this case also with the scan line address. In this manner, the DP8350 series has a maximum address capability of 16 bits (64k).

#### VARIATIONS

If memory mapped graphics is desirable but standard alphanumerics is also required, combination of these techniques is possible. For example, if only a small portion of the CRT screen need be memory mapped and the remainder can be character generator alphanumerics and/or graphic symbols. In this case a higher order data bit from CRT memory defines whether the lower order data bits are graphics video data or ASCII and graphics symbol code. Figure 7 is a block diagram of such a system.

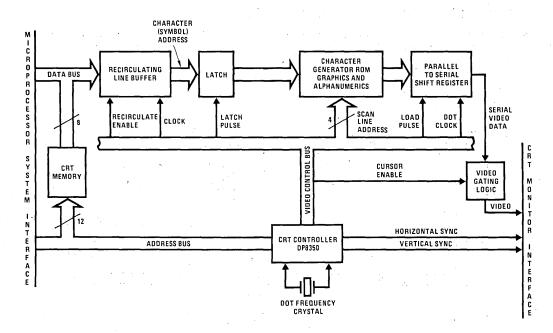


FIGURE 5. Character Generator Graphics (With Line Buffer)

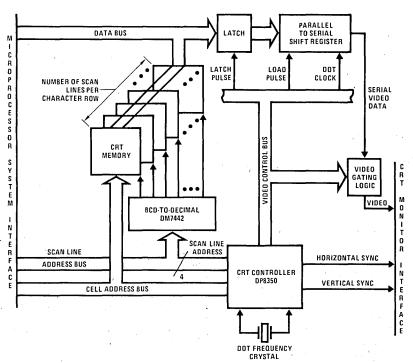


FIGURE 6. Dot by Dot (Memory Mapped) Graphics

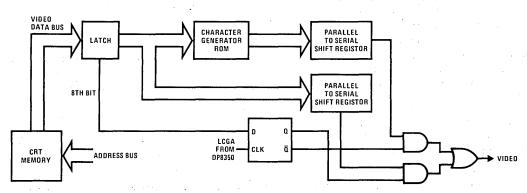


FIGURE 7. Combined Character Generator and Memory Mapped Graphics.

#### SUMMARY

This application note has demonstrated 2 basic graphics techniques that may be implemented using the DP8350 CRT controller. Variations to these techniques are possible such as changing character cell sizes and subdividing the character cell into dot blocks. In most cases, these variations are done to decrease hardware or software overhead. Since the DP8350 series of CRT controllers offer display format flexibility through internal ROM program variations—the device adapts equally well

to these graphics variations as it does to the standard applications.

The fact that all the required control functions for the "video loop" are contained within the same chip—the DP8350—makes it very effective in these types of applications; as a result it will produce the minimum chip count and cost.

## Graphics/ Alphanumerics Systems Using the DP8350

National Semiconductor Application Note 243 Mike Evans April 1980



This application note summarizes some CRT terminal circuits, each with an increasing degree of graphics capability, and then goes into detail to describe a system having full graphics capability, with all dots individually programmable. All these applications use the DP8350 CRT Controller.

Here are some of the features of the full graphics system.

#### Hardware Features

- The hardware is designed for a 24 row by 80 column display, with 7 dots per column and 10 lines per row
- · All ICs are made by National Semiconductor
- · Low I.C. cost, all parts readily available
- · Fits on one standard BLC80 (SBC80) card
- System performance only limited by software
- 8080 Mnemonics useable with STARPLEX or Intellec Development Systems
- All graphics programs very fast Example: One dot takes 500µs maximum to plot
- During display time, each 7-dot cycle may be shared by the microprocessor
- 8 bit word comprises MSB as attribute and next
   7 bits as 7 dot word of a character line
- · Can input display data serially or parallel
- Can output display data serially or parallel
- Baud rate programmable from 110 to 56k baud
- · Can be used as slave to main system
- Can copy characters from alphanumeric ROM or symbol EPROM
- 13k bytes of RAM available for user software or back-up display storage
- Analog inputs joystick or waveforms
- Easily expandable to color graphics

The DP8350 CRT Controller provides incrementing video addresses starting from the Top of Page address, or from a new Row Start address. These addresses and the Cursor address are loaded into their respective registers from the address bus. All video control signals are provided by the 8350, so that apart from the crystal oscillator, no extra video circuitry is required.

#### Software Features

- The software is programmed for any display configuration of rows, columns, dots per column and lines per row. The hardware is designed for a 24 row by 80 column display, with 7 dots per column and 10 lines per row.
- Can perform most dumb terminal functions, including scrolling
- Simultaneous display of alphanumerics and graphics
- Identical terminals can display same information with inputs from either
- · Can save displays in computer storage
- · Can load displays from computer storage
- . Can erase any part of display or all of it
- Can draw a rectangle linking any 2 horizontal and 2 vertical coordinates
- Can transfer in 1/10th second max any area of display to any other area or to/from back-up display storage
- Smooth movement of subject in any direction
- · Immediate display of fixed diagrams
- · In-system emulation of programs available

The DP8350 has so far been considered to be useable only in dumb terminals, whereas in fact is is easy to adapt it to more complex terminals with full graphics capability. Following is a summary of the functions of the various combinations of alphanumerics/graphics displays beginning with a dumb terminal using a monitor with 24 × 80 characters.

#### **Dumb Terminal**

The basic dumb terminal design is shown in Figure 1. Usually the microprocessor loads the Character Position RAM (or Refresh RAM) only during horizontal or vertical blanking, or during the last 3 lines of a row. The CRTC then sequentially addresses this RAM during display time. The ASCII data from this RAM (for the character selected) is outputted to the ROM of the Character Generator. The 7-dot word of this character for the line being displayed is then loaded into a shift register, and shifted out as video to the monitor during the next 7-dot cycle. The ROM, line counter and shift register can be one IC, such as the DM8678 DAB Character Generator, which contains all ASCII upper case characters.

The logical choice of CRT Controller for this simple CRT terminal is the DP8350, which mates perfectly with the DM8678. The most common application is for a 24 row by 80 column display with the character field comprising of 10 lines each of 7 dots. The character itself occupies 7 lines each of 5 dots, leaving 3 lines for vertical character spacing, and 2 dots for horizontal character spacing.

Refer to AN198 and AN199 for further information on alphanumeric applications of CRTs.

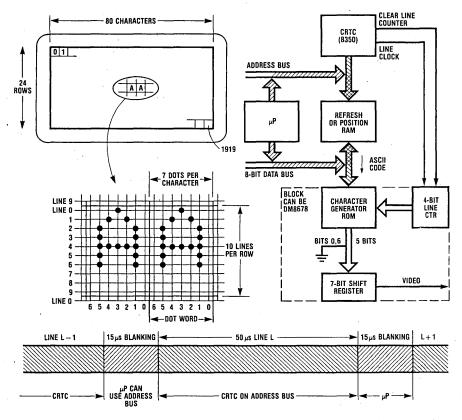


Figure 1. Simplest CRT Terminal

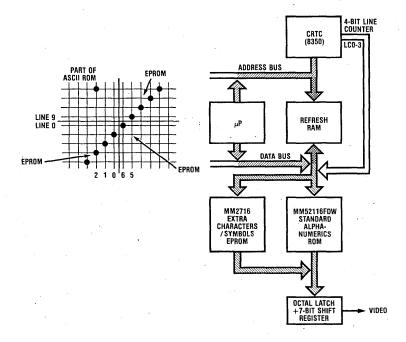
#### Disadvantages for Graphics

- . Only characters in the Character Generator ROM can be selected
- Characters not continuous to adjacent fields
- Microprocessor thru put 30% of maximum not desirable for graphics

# Alphanumeric Characters with Extra Symbols

When characters or symbols are required that are different from those in the ROM, then an extra EPROM such as the MM2716 can be added as shown in Figure 2. The standard characters can be selected from a separate ROM such as the MM52116FDW which contains all 128 standard ASCII characters. The EPROM is preprogrammed with additional characters or symbols. The 8350 outputs sequential addresses to the Refresh RAM, and each address is two dot cycles ahead of the shifting dot word.

The data out from the RAM must be valid 150 ns after each address change. The MSB of the data selects ROM or EPROM, and the remaining 7 bits select the character. The line of the character is decoded from the 4-bit line counter outputs coming from the 8350. The ROM/EPROM now has 640-150 ns (> 450 ns) to output the valid dot word. This has to be latched into an octal latch and held for one dot cycle before it can be loaded into the 7-bit shift register. The dots are then shifted out in the dot cycle.



#### Refresh RAM MSB:

- 0 selects alphanumeric ROM
- 1 selects symbol EPROM

Figure 2. Fixed Character ROM + Symbol EPROM

#### **Disadvantages For Graphics**

- Fixed graphics possible with continuous display, but limited to 128 different characters, and 128 standard alphanumerics, for all 1920 positions.
- · Also it is not possible to change characters/symbols once the EPROM has been programmed.
- The Microprocessor is still slow thru-put.

#### **Limited Graphics Terminal**

To be able to generate *any* graphics symbol, a character RAM must replace the fixed ROM characters. Characters or symbols can be loaded into the RAM as required from a ROM or a pre-programmed EPROM like the MM2716 (refer to Figure 3). But now, new graphics characters can be written into the RAM from the Microprocessor. These can either be derived internally from the  $\mu$ P or obtained directly from peripherals (such as serially to an Asynchronous Communications Element like the INS8250, or parallel from an external I/O port).

This limited graphics application thus requires two RAMs, the Refresh RAM (or Character Position RAM), and the Character RAM. The Refresh RAM outputs the selected character address, and the 8350 line counter outputs select the line in the Character RAM. The 7 dots outputted from this RAM are latched into the Octal Latch and held for one dot cycle. The 8th bit of data can be used as an attribute control bit. The 7 LSBs are then loaded into the 7-bit shift register.

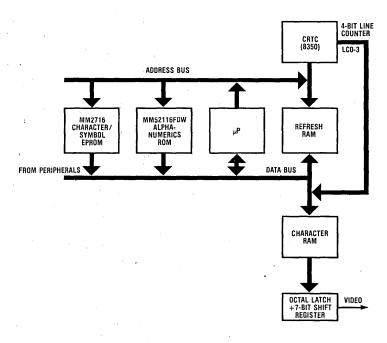


Figure 3. Character RAM with ROM/EPROM Look-Up

#### Disadvantage for Graphics

. Only 256 possible characters per display, with the 8-bit data bus, but can re-load different characters for a new frame.

#### Advantages

- Can now load standard characters or symbols from EPROM, either at switch-on or during normal running.
- Can also load characters/symbols/graphics from the μP or peripherals, e.g., to create graphics drawings to connect to adjacent positions.
- Can now be a very fast system by isolating the μP address bus from the CRTC address bus, the μP can share the dot cycle with CRTC.
- . Refresh RAM and character RAM can be made the same IC by using one 8k × 8 quasistatic RAM.

With the new  $8k \times 8$  quasistatic RAMs such as the NMC4864, the first quarter can be used as a Refresh RAM for the 1920 character positions. The RAM data outputs containing the character address can then be latched into an octal tri-state latch. If the 8350 address bus is then disabled, the octal tri-state latch can feed back to the RAM second half address inputs, along with the enabled 8350 line counter outputs. The data out from the RAM now contains the next 7-dot word to be displayed and this is then loaded into the shift register. This takes the last two thirds of the dot cycle, the first third is for the  $\mu P$ . With the fast cycle time of the quasistatic RAMs this 3 part cycle can easily be accomplished in one 7-dot cycle. (Refer to Figure 4.)

With the method just described it is only possible to display 256 different characters for any one page, because each character consists of 10 lines, almost filling the second half of the quasistatic RAM. If this is acceptable, then a limited graphics terminal can be easily implemented using a microprocessor, with one MM2716 instruction set EPROM, one MM52116FDW character ROM, one MM2716 symbol EPROM, one DP8350 CRT Controller, the NMC4864 quasistatic RAM, and a DM74166 shift register. The logic and drive circuitry required to control the sequencing comprises a further 15 SSI ICs. This application has not yet been built, awaiting availability of the quasistatic RAMs.

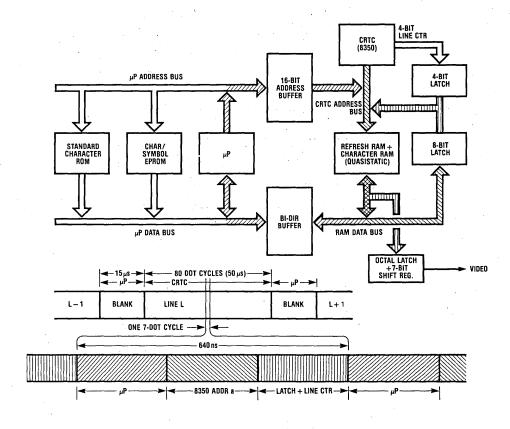


Figure 4. Limited Graphics Using a Buffered CRTC Address Bus and a Quasistatic RAM

#### Advantages

- . Only one IC, an 8k x 8 quasistatic RAM, used for both the refresh RAM and character RAM
- Fast, although μP may be in the wait state for a maximum of 600ns. This is no problem because the fastest μP instruction cycle is 1μs, so there will be no effect on maximum thru-put.

#### Disadvantages

- . No quasistatics available at the time of writing
- Full graphics capability not possible

#### **Full Graphics Capability**

We need to be able to select any dot on the display, for full graphics capability, while still using the CRT controller to sequence every line of every row, as it does in the simple terminal (See Figure 5).

With the standard  $24 \times 80$  character display, full graphics can be achieved by using a 24 (rows) by 80 (columns) by 10 (lines) address RAM, and selecting the 7 dots as the data word for the character position on the display and the line of that character position.

This means that alphanumeric characters can be displayed in exactly the same format as with a simple terminal, by copying the character from ROM or EPROM into the selected 10 line by 7-dot field, line by line.

Full graphics capability is also easily implemented once the relevant software algorithms have been determined.

So for full graphics, every dot is one bit of memory. There is no refresh RAM, refer to Figure 6. The CRTC scans through the Display RAM, a line at a time for each row on the CRT, causing the RAM outputs to be read every 7 dot cycle. The RAM output is shifted out two dot cycles later. The microprocessor may write into the Display RAM each 7-dot word, with "1's" representing dots.

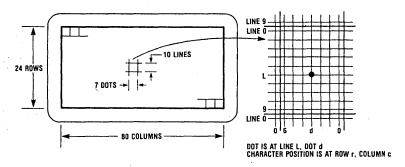


Figure 5. Full Graphics Capability Requires Individual Dot Selection

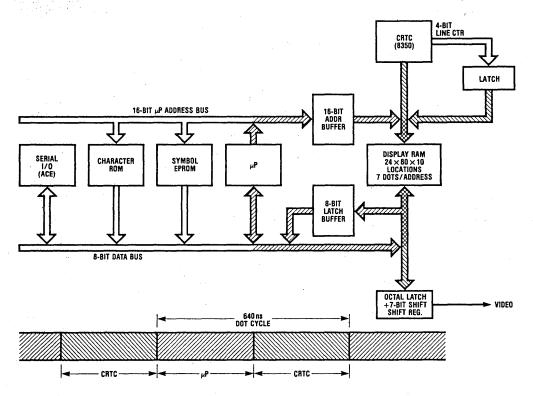


Figure 6. Full Graphics System

#### **CRTC Address Bus Configuration**

The particular RAM address to be written into is determined by its  $10 \times 7$  character field position and the selected line of that field; refer to Figure 7.

The 11 least significant addresses  $\rm A_0$  to  $\rm A_{10}$  contain character position information from position 0 to 1919,

and the next 4 addresses  $A_{11}$  to  $A_{14}$  are the 8350 line counter outputs via a tri-state buffer. The most significant bit,  $A_{15}$  is used to select the RAM when HI, and the EPROMs and peripherals when LO

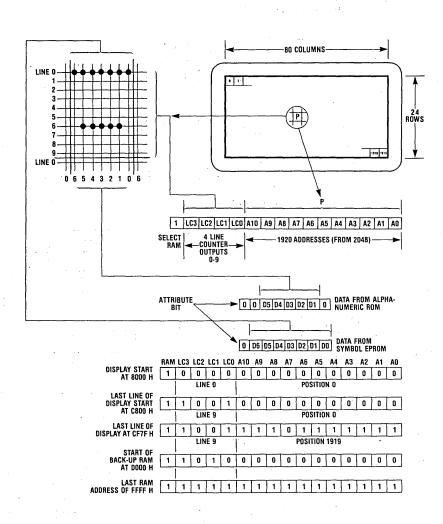


Figure 7. RAM Addressing

#### Graphics Design Criteria

In the simple CRT applications, the microprocessor is used mainly to re-write the Refresh RAM as new information is fed in, either from the keyboard, or from the main computer (via ACE). The µP can still be used in this application for alphanumerics/graphics, but it is also desirable if it can perform graphics computations, such as drawing lines from the inputted coordinates.

This requires the microprocessor to be able to write 7 dot words quickly to the Display RAM. The best way to implement this is to time multiplex the dot cycle with the CRTC so that whenever the µP requires access to the Display RAM, it merely waits for its slot in the next dot cycle, which could be up to 640 ns later. The information is either written or read after 360 ns. that is a maximum of  $1\mu s$  after the memory access request, which is fast enough. Now the µP no longer has to wait for blanking to be able to operate, it continues its normal operation and only enters the WAIT state during RAM access. Although this is for up to 1 µs, in fact it is in general invisible because the µP memory access takes at least 700 ns.

#### The Microprocessor

The 8080A-2 was chosen for the following reasons:

- FAST takes 21.84 MHz (2 × 8350 frequency) divided by 9 (in the 8224), to give a clock cycle of 2.427 MHz, i.e.,  $0.41\mu s$  per microcycle, or  $1.6\mu s$  for a short instruction
- Software can be developed on STARPLEX™ or Intellec Development Systems
- INS8080A-2, DP8224 and DP8238 are low cost and available from National
- Associated circuitry previously designed Application Note AN199

Note the DP8238 has advanced MEMW mode desirable so that the microprocessor can go into the WAIT state earlier in the write cycle.

#### interrupts

The INS8259 is ideal as as an Interrupt Controller, because most interrupt signals in the system are positive going, saving D-type flip-flops. It can also be used to mask off interrupts when necessary.

#### Interrupt Priority

1) Horizontal Sync from the 8350, highest priority if row start has to be guickly changed, normally masked off

- 2) Paralleled 8-Bit I/O Port, highest priority if CRTC card is part of a master system, otherwise masked off
- 3) Vertical Sync from the 8350, normally highest priority, need to quickly change the Top of Page register for scrolling, to change the display before the new frame begins
- 4) ACE, INS8250 during serial block transfers this will take highest priority
- 5) Keyboard the time to press the keys is much longer than the interrupt wait time so can be low
- 6) A/D Converter time for conversion is 100 µs so again can be low priority

#### Display RAM

The system requires a RAM with  $24 \times 80 \times 10$  addresses, each of 8 bits (representing 7 dots + 1 attribute bit), and a cycle time of 640ns/2 or 320ns. Using static RAMs 19.2k bytes would require 40 ICs, whereas using dynamic RAMs 16 ICs are necessary, totalling 32k bytes. This leaves 13k bytes available as spare RAM.

#### Advantages of Dynamic RAMs

- Only 16, 16-pin packages instead of 40, 18-pin packages
- Less than \$10 for 16,000 bits
- Fast access and cycle times using the MM5290-2 (average cycle time is 320 ns). Even faster times with the 5V only 16k MM5295
- Standby current only 5% of operating current
- Less average power dissipation than for static RAMs

This means average power dissipation is  $30 \,\mathrm{mA} \times 12 \,\mathrm{V} \times$  $\frac{1}{2} \times \frac{1}{2} \times 16$  or 1.5W for all 16 packages (only one bank is accessed per cycle by the CRTC for half the dot cycle time). For 40, 4k x 1 static RAMs, average power is  $80 \text{ mA} \times 50 \text{V} \times 40$  or 16W. Note that if the MM5295 5V, 16k × 1 dynamic RAM is selected, power dissipation will be even further reduced, with access and cycle times about half the 3 rail version.

#### Disadvantages

- Not easy to interface to
- Need to be refreshed every 2ms see "Refreshing of Dynamic RAMs"
- 3 supply rails needed, +12V, +5V, -5V, but these are already required for the 8080

#### Refreshing of the Dynamic RAMs

With 16k dynamic RAMs all 128 rows of every RAM have to be refreshed every 2ms maximum to maintain valid data. It is possible to manipulate the addressing of the CRTC address bus to the dynamic RAM multiplexed address bus, so that there is no need for a separate refresh counter. This is because for any display row, the 8350 sequences all 80 characters, starting at line 0 and ending at line 9. Thus we can use the 3 least significant bits of the line counter outputs (A<sub>11</sub>, A<sub>12</sub>, A<sub>13</sub>, from LC0, LC1, LC2) for three of the dynamic RAM row address bits, (corresponding to lines 0 to 7 of each display row), and the four least significant bits of the character position address (A<sub>0</sub> to A<sub>3</sub>) for the remaining four RAM row address bits. See Figure 8.

Unfortunately, because 19k addresses are required, it is necessary to use two banks of RAM (8 RAMs in each bank), giving a total of  $32k \times 8$ . This leaves 13k bytes

available for scratch pad, display storage, and insystem emulation of programs. Therefore each row of this second bank of dynamic RAMs also has to be refreshed. By using address bit A4 to select the bank, all rows of the dynamic RAMs are therefore refreshed every 32 characters, which in fact is eight lines, or in effect one row of the display. The worst case is when the 32 characters are split over two display rows. There is no problem during the vertical blanking because the 8350 still outputs incrementing addresses and LCGA continues to activate the control logic. So refreshing still continues during blanking. Thus the longest period any RAM row goes without a refresh cycle is 65 µs per line  $\times$  10 lines per row  $\times$  2 rows = 1.3ms, which is still within the 2ms maximum at 70°C. In other words, dynamic RAM refreshing is automatically performed by the 8350 sequencing the address and no extra circuitry is required.

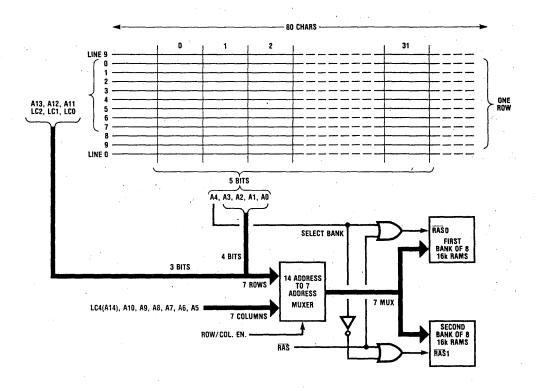


Figure 8. Automatic RAM Refresh

A graphics/alphanumeric CRT Controller requires the following (See Figure 9):

- 1) All monitor signals provided the 8350 provides Vert/Horiz sync and vertical banking
- 2) Cursor signal the 8350 has cursor enable
- 3) Fast dot clock, a 7-dot cycle clock continuous, and a shift register clock only during display - the 8350 has dot clock, LCGA and LVSR
- 4) Line counter output 4-bit, tri-state the 8350 has line counter output (but not tri-state)
- 5) Ability to set top of page, row start and cursor reg at any time - the 8350 can do this using LD REG, RA and RB inputs during the time the  $\mu P$  is on the CRTC address bus. RA and RB can be data bus bits DB0 and DB1, and LD REG can be decoded from the address bus

- 6) 50 Hz or 60 Hz capability the 8350 has a frequency select input
- 7) Incrementing position address, tri-state the 8350 has this, with a maximum enable/disable time of 30 ns

This parameter is important in this application where it is necessary to switch the memory from the CRTC address to the microprocessor address, and back to the CRTC address all in one 7 dot cycle of 640ns. Other CRT controllers are not capable of enabling and disabling the CRTC address so quickly.

Hence the DP8350 requires no extra circuitry apart from a Quad Latch to disable the Line Counter outputs. The 8350 has internal ROMs which determine how many rows (24), columns (80), lines per row (10), and dots per column (7). Versions of the 8350 are available with other combinations.

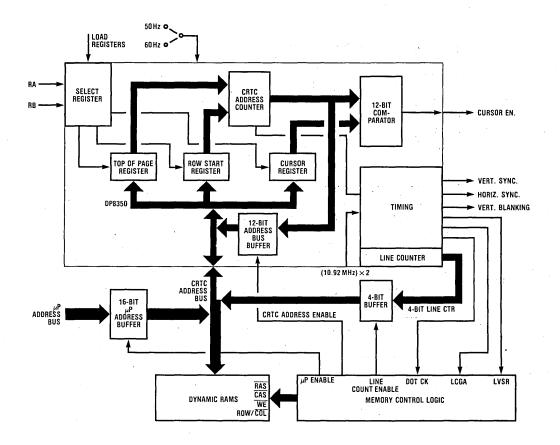


Figure 9. 8350 Block Diagram

#### **System Timing**

The standard timing for the dumb terminal type of application is shown in the timing section of Figure 1, with the microprocessor inactive during display time. This is undesirable for graphics applications where full use of the microprocessor is required for computations and peripheral control with very fast baud rate. To determine the timing sequence it is first necessary to calculate the CRTC frequency required for the dot clock.

CRTC Frequency =  $d \times [c + (characters during horizontal blanking)] \times [(r \times I) + (lines during vertical blanking)] \times (line input frequency)$ 

where d = dots per character, c = columns on display r = rows on display l = lines per row For the standard 8350,  $f = 7 \times (80 + 20) \times [(24 \times 10) + 20] \times 60 \text{ Hz}$  $= 7 \times 100 \times 260 \times 60 \text{ Hz} = 10.92 \text{ MHz}$ 

This is too slow for the DP8224 which divides the crystal frequency by 9 to provide the clock to the microprocessor. The 8224 frequency can therefore be 21.84 MHz as in Figure 10, and this is divided by 2 to provide the 8350 dot clock of 10.92 MHz, or 91.6 ns per dot. A 7-dot cycle is 641 ns or 1.560 MHz. This is divided by 2, i.e., 780 k Hz, to provide a clock frequency for the A/D converter.

The 8080 frequency is 21.84/9 MHz or 2.427 MHz. This frequency is also applied to the ACE to provide the clock for the Baud Rate divider. The baud rate is determined from  $2.427\,\text{MHz}/(16\times\text{Baud Divisor})$ .

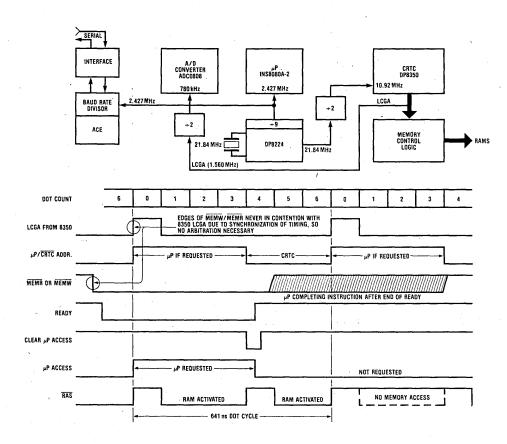


Figure 10. System Timing Control Circuit and Diagram

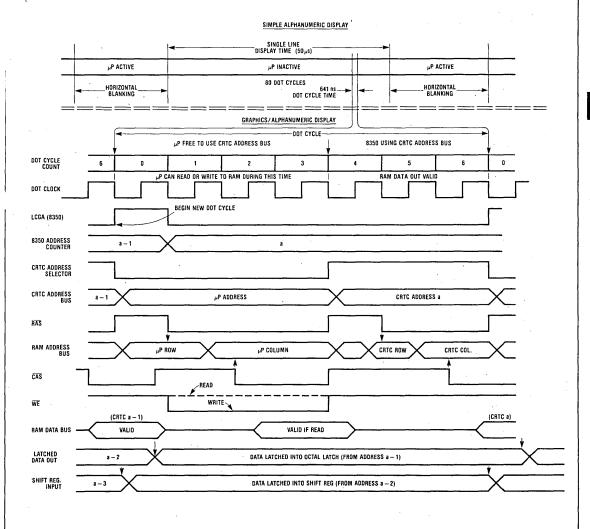
#### 7 Dot Cycle Timing

Figure 11 shows how the 7-dot cycle time of 641 ns can be time multiplexed into two separate control sequences; Microprocessor and CRTC. It is necessary that the new 7-dot word to be displayed, is available at the commencement of the dot cycle shift. Therefore the 8350 must access the CRTC address bus for the second half of the 7-dot cycle, in fact for the last 3 dots of the cycle. This allows the time period taken by the first 4 dots to be used by the microprocessor, so that the microprocessor address output appears on the CRTC address bus for the first four dots, but only if a  $\mu P$  access is requested.

The CRTC 15-bit address is time multiplexed into 7 rows and 7 columns to be applied to the dynamic RAMs, using 2 DS3648 muliplexer-drivers, with bit A4 selecting the bank. It is therefore necessary to latch in first the rows with RAS (Row Address Strobe), and then the columns with CAS (Column Address Strobe), for both the  $\mu P$  half-cycle and the CRTC half-cycle. All the set-up

and hold times are met by the circuitry of Figure 12. If the  $\mu P$  is not requesting RAM access during its half-cycle, then RAS does not occur, although CAS still does. This is because RAS enables CAS internally in the dynamic RAMs, so that if RAS does not occur, the CAS has no effect and the RAM remains in standby mode. This is also the case in selecting the banks with RAS0 or RAS1.

In the second half-cycle, the CRTC always reads the RAM, so WE remains HI, but in the first half-cycle the  $\mu P$  may request a READ or WRITE. WE remains HI for READ, and for WRITE remains LO while RAS is low. Note that the 8350 outputs the address word two dot cycles in advance, and therefore it is necessary to latch and then hold the dot word for one dot cycle. It is then latched into the 7-bit parallel-in serial-out shift register. The 8th bit from the latch can be used as an attribute bit.



5-59

Figure 11. Memory Control Logic Timing Diagram

Figure 12 shows the Memory Control Logic required to correctly sequence the control signals and busses to the dynamic RAMs and associated components. The interfacing from the 8080 microprocessor (via signals MEMR and MEMW) is such that whenever the  $\mu P$ requests to read or write to the dynamic RAMs, the µP Access Flip-flops access the RAMs at the start of the next µP cycle. At the end of these four dots, the information has either been latched into an 8-bit latch (for READ), or written into the RAMs (for WRITE). The READY signal goes active at this time which ensures that valid information is read at the end of the uP cycle: refer to Figure 10. Also the fact that MEMR and MEMW occur at fixed intervals relative to the dot cycle signal. LCGA, means that system contention cannot occur. Therefore there is no need for arbitration between these two signals when a microprocessor cycle is requested.

This also applies when selecting the 8350 to change Top of Page, Row Start and Cursor. To select any of these 3 registers, the  $\mu P$  data bus bits D0 and D1 are connected to  $R_A$  and  $R_B$  to select the required register.

The information to be latched into the selected register has to be valid on the the CRTC address bus. Because this is time shared with the 8350 address counter, which outputs the incrementing display addresses during the second half of every 7-dot cycle, the CRTC register information has to be valid for the first half of the next dot cycle. The CRTC is selected with DS6/7 and MEMW, so that REGISTER LOAD occurs just after the CRTC register information becomes valid on the CRTC address bus. The 8350 spec requires that the address be valid 250ns before REGISTER LOAD trailing edge (old data sheets do not state this), and that  $\rm R_A$  and  $\rm R_B$  are valid at the leading edge. Note that the 8350 internal address counter can be enabled or disabled within 30ns of the ADDRESS ENABLE changing state.

All the Logic for Memory Control is Schottky, due to the very fast timing required in the system. Note that the cycle time of the CRTC half-cycle is 270 ns, which is less than the 320 ns specified for the MM5290-2. This parameter is specified at 320 ns for power dissipation reasons, and because the  $\mu P$  is not fast enough to use its half-cycle every 7-dot cycle or 641 ns, the average cycle time is greater than 320 ns

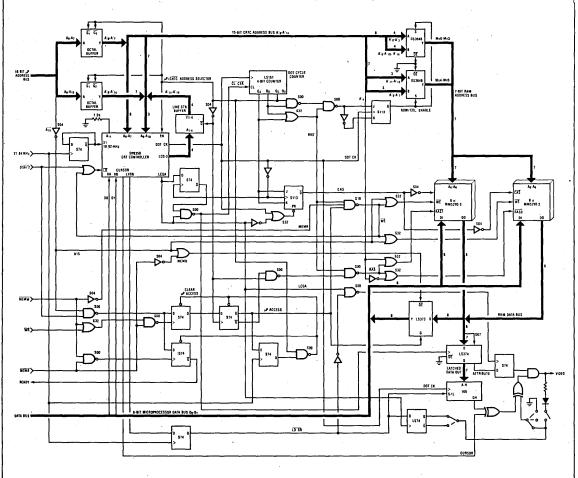


Figure 12. 8350 Graphics Memory Control Logic

#### System Configuration

Figures 13 and 14 together show the system block diagram. The peripheral components of Figure 13 are used with the microprocessor circuitry of Figure 14. The right hand half of Figure 14 is equivalent to the circuitry of Figure 12.

The LS138 address decoder is used for both I/O and memory addressing. Referring to Figure 15 address map, the peripherals are designated as I/O, and the EPROMs, ROM, CRTC and dynamic RAMs as memory. With address bit A15 HI, the 32k dynamic RAM block is selected. With address bits A14 and A15 LO, the LS138 outputs are selected. A11, A12, and A13 are decoded to

select which one of the LS138 outputs goes LO, so that when memory is addressed, each section is 2k bytes. This includes the CRTC which requires 4k bytes from 3000H to 3FFFH for 2 pages. The top four address bits select the CRTC and the remaining 12 address bits are latched into the selected register.

When addressing I/O, address bits A0-A7 also appear respectively on A8 to 15, so that with A6 and A7 LO, i.e., I/O address 00H to 3FH, each LS138 output is now 8 bytes selected by A3, A4, and A5. Bits A0, A1, and A2 are then connected as required to the peripherals, to select the addressed byte.

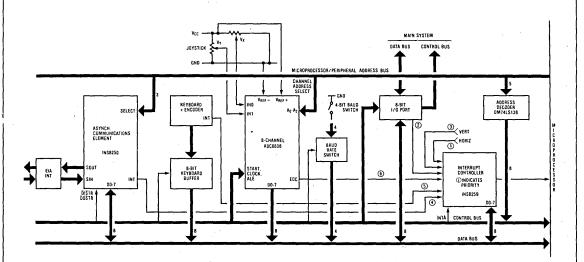


Figure 13. Interfacing to Various Peripherals

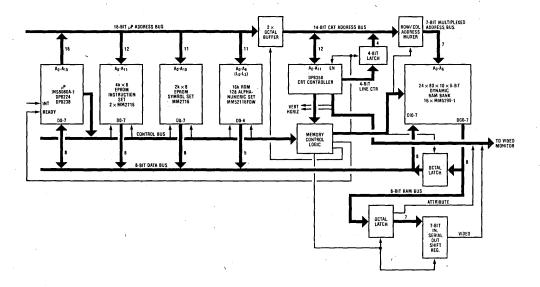


Figure 14. Complex Alphanumeric/Graphics/Symbol Display Terminal

#### **Peripherals**

#### I/O Port

IN 00H or OUT 00H select the 8-bit parallel I/O port, which basically is two octal latches with tri-state outputs. The 8 output bits may be connected to a master 8-bit data bus. When an external 8-bit data word is latched into the input octal latch, an interrupt causes this to be enabled on the  $\mu P$  data bus, when acknowledged with the instruction IN 00H. To output to the master databus, OUT 00H causes the  $\mu P$  data to be latched into the output latch and this also provides an external interrupt to the master system. The master can then read this data by enabling the output octal latch. Data can be transferred fast because the I/O port normally has the highest priority interrupt (IR 3 of the 8259), when required.

#### Interrupt Controller INS8250

This was also mentioned in an earlier section. At initialization, it is set up to remain in the fully nested mode, so that only higher priority interrupts may interrupt an existing interrupt. Otherwise a lower priority interrupt has to wait for the higher one to finish. Normally the horizontal sync interrupt to IR2 is masked off if there is no need to change ROW START or soft scroll display data off the screen line by line. The I/O address to select the 8259 can be either 10H or 11H; refer to the 8259 data sheet and the software to determine whether A0 is '0' or '1'. Each interrupt routine has to end with a SET END OF INTERRUPT instruction.

#### Keyboard

The instruction IN 18H reads the ASCII data on the keyboard after a keyboard interrupt has been acknowledged.

#### Serial I/O Using the ACE INS8250

The INS8250 with its associated EIA RS 232 interface allows serial data to be received or transmitted 8 bits at a time, with the instructions IN 20H or OUT 20H. The baud rate is previously determined as described in the software section. Other ACE registers may be accessed, by connecting A0, A1 and A2 of the  $\mu P$  address bus to the same designations on ACE, so that ACE addresses are from 20H to 26H. During block transfers, such as dumping a picture on the screen into an external memory, or loading from the memory, the higher priority inputs can be masked off for fast transfers.

#### **Baud Rate Switch**

See 'Baud Rate' for application, the instruction OUT 28H will read the 4 switch positions.

#### A/D Converter ADC0808

This 8 analog channel, 8-bit A/D converter, has first to be initializeded to commence a conversion on one of the channels. Address bits A0, A1 and A2 are used to select the channel, so that instruction OUT 3nH starts a conversion on INPUT n. The conversion takes about  $100\,\mu s$  with the 780 kHz clock, so the  $\mu P$  can continue operating during conversion. The END OF CONVERSION signal then interrupts the  $\mu P$ , which when acknow-

ledged reads the 8-bit data with the instruction IN 3nH, although n is not important in reading the A/D.

The A/D converter being only one 28-pin chip, is ideal for demonstrating the graphics capabilities of the system. For instance, an x-y joystick can be connected to INPUT 0 and INPUT 1, so that the movement of the joystick draws on the screen.

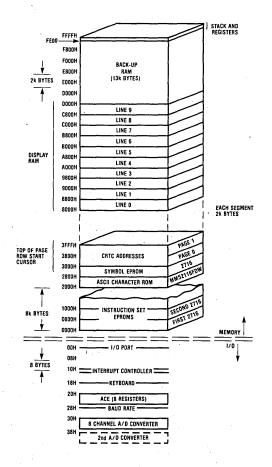


Figure 15. I/O and Memory Map

#### System Operation and Software

The software was developed purely for demonstration purposes to show the versatility and power of the system. All the software has been tested, but the system could be much more powerful with additional software. The 13k bytes of back-up RAM are also useful in this respect. The software was developed on National's STARPLEX<sup>TM</sup> Development System. The instruction set so far is just under 4k bytes, so two 2716's are used, but these may be replaced by 2732's if the chip select pins are reconnected, so that extension up to 8k bytes is possible with no extra IC sockets.

#### **Parameter Definitions**

The software is structured as in Figure 16. The philosophy was to make it versatile, easy to understand, and easy to modify or add to.

The registers are stored in the dynamic RAMs starting at FE00H in the non-display section. The Top of Stack is also in the RAMs at the highest location, FFFFH. This allows for about 240 nested two-byte PUSHes or CALLs, which is comfortable. Any register may easily be relocated merely by changing its address, similarly any new registers may be added to the list.

The addresses of the various memory and I/O locations are also listed and defined in the front section so these can be changed as desired.

For complete versatility, the display parameters are also listed in the front section so that any different value of parameters from those listed need be changed only in this section. The values of the parameters or constants are those of the standard DP8350 around which the hardware has been designed.

Thus by defining most parameters in the software once, at the beginning, the subsequent routines/subroutines will be valid for different applications and should not need to be altered, merely added to. Not many macros were used in order to save EPROM instruction space.

#### Interrupt Entry Locations

These are in 8-byte increments beginning at 0010H. The 16 bytes before this are saved for power-up initialization to disable interrupts and set Top of Stack.

Each interrupt location calls that interrupt subroutine. At the end of the subroutine, the system returns to output an END OF INTERRUPT to the 8259, and then returns to the original subroutine in progress when the higher priority interrupt occurred. If no interrupt was in progress, the program returns to the WAIT LOOP which enables all unmasked interrupts to the  $\mu P$ .

#### Look-Up Tables

This has three sections. First, the BAUD RATE DIVISOR look-up table contains all the 16-bit divisors required for baud rates from 110 baud to 19k baud.

The next look-up table contains PROGRAM LABELS, used in the SEARCH FOR PROGRAM subroutine. The first row contains all the first characters of the program labels, the second row contains the second character, up to the fourth row contains the fourth character. Each program consists of four characters.

The third table is the address list so that once the SEARCH subroutine has located the desired label, it alters the program counter to the equivalent section of this table, which then calls up the program requested.

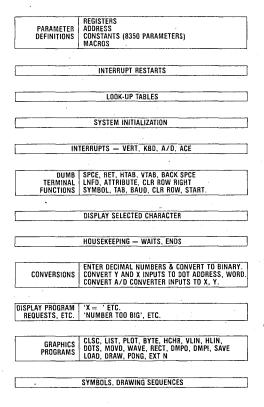


Figure 16. Graffiti - Software Structure

#### System Initialization

After disabling interrupts and setting Top of Stack, the 32k addresses of RAM are cleared one byte at a time, so that the screen is blank within half a second of switch-on. The cursor is then homed to the first character position. First the Top of Page register is set to 0 in the CRTC and then the cursor register is set to 0, both in the RAM and the CRTC. The column count is also reset.

The ACE is next set up including the baud rate (see Baud Rate section). Next, the Interrupt Controller is set up, and after this the system enters the WAIT LOOP system, enabling the interrupts to wait for an interrupt.

#### Interrupts

- Horizontal Interrupt is normally masked off but may be unmasked for two reasons: either during scrolling, so that each row can be soft scrolled off the screen a line at a time, or during editing to delete a row, so that a jump in ROW START to the next row has to occur every frame at this new row. This new row must be loaded after horizontal blanking of the last line before the jump row is to begin.
  - Note that if the ROW START register is not loaded, each row start address is the last display address incremented.
- Port Interrupt is normally masked off, but must be unmasked if transfer of data to a master system is necessary.
- 3) Vertical Interrupt is used for two purposes. One is to scroll the display by one row, once the scroll semaphore bit has been set in one of the associated subroutines, this is begun at vertical interrupt so that screen flicker does not occur. The other is to change a graphics display every frame so that smooth transition of a subject across the screen is attained. An example of this is the program PONG. The flow chart for Vertical Interrupt is shown in Figure 17.
- 4) ACE Interrupt is by far the most complex because data received by this chip then has to be operated on to determine what action to take. The flow chart for ACE Interrupt is shown in Figure 18. Assuming the interrupt is because ACE has received data available, the ASCII data is checked for a function input. If not a function, but a program is already in progress awaiting inputted data, then this character is saved in the Input Character register. If the character was entered while the cursor was in the first four positions of a row, then the character is saved in a register determined by the column position of the cursor. This saves the character to recall it in a lookup comparison later, while searching for a program. Unless the ASCII code was a function, the character is displayed in the cursor positon (see Displaying Characters).

- If the ASCII code entered is a function, then first CARRIAGE RETURN is checked for. If negative, then all the other functions are checked for and if positive, that particular function is executed. If the input is in fact a carriage return, then a check is made to see if the cursor was in the 5th position, signifying a four character graphics program has been requested. The system then goes to search in a look-up table for a program corresponding to the four ASCII characters entered in order. If a program is found, the system then calls the requested graphics program and executes it. If not, then a carriage return is executed.
- Keyboard Interrupt in most systems is a simple subroutine, merely accepting the ASCII data word from the keyboard and outputting it to the ACE (see Displaying Characters).
- 6) A/D Converter Interrupt sets the A/D semaphore bit.

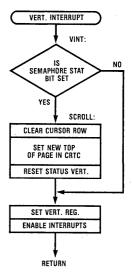


Figure 17. Vertical Interrupt Flow Chart

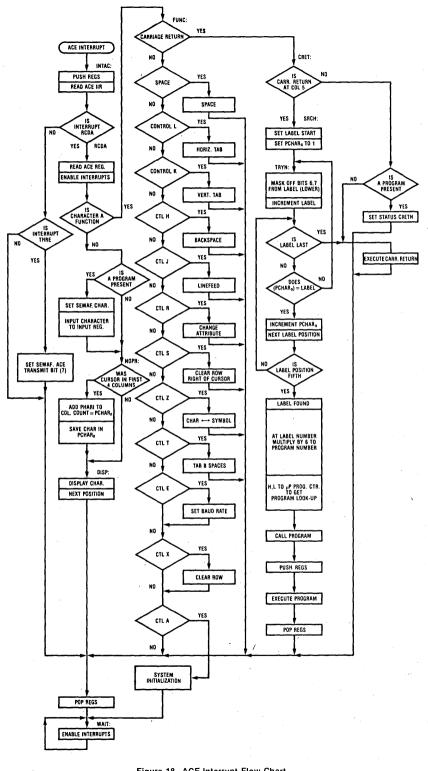


Figure 18. ACE Interrupt Flow Chart

#### **Functions**

A number of dumb terminal functions are available with the present software: carriage return, line feed, advance cursor, backspace, up cursor, tab 8 postions, clear row, clear row right of cursor, scroll up one row, and selecting attributes. Attributes available are half-intensity characters and character inversion. Each 7-dot location has its own attribute bit.

#### **Baud Rate**

The 4-bit BAUD SWITCH is used to select the BAUD RATE at switch on, or during operation if CTL E is entered. The  $\mu$ P then reads the switch setting and loads the corresponding 16-bit BAUD RATE DIVISOR into the INS8250 Asynchronous Communications Element. Baud rates from 110 to 19k are available, and up to 56k is feasible if the 8080A-2  $\mu$ P is selected for fast data rates.

#### Displaying Characters

When a key is depressed, the keyboard outputs the ASCII code of the key selected, which is read by the  $\mu P$  when the keyboard interrupt is acknowledged. The  $\mu P$  then outputs the same ASCII data to the INS8250 ACE to be transmitted serially via the RS232 interface. This can be connected to a main computer, or an identical terminal, or back to the serial input of the ACE. When the ACE receives the returning 8 bits, it outputs a RECEIVED DATA AVAILABLE INTERRUPT or RCDA. The received data is then read by the  $\mu P_1$  which selects the ASCII character from the 128 character ROM (MM52116FDW) using the ASCII code as address. The alphanumeric character is copied line by line into the dynamic RAM in the position of the cursor.

Initially all RAM locations are '0' and the dots are written as '1', in a 7-dot word. See Figure 19. Then every frame, as the 8350 scans each line, the 7-dot word for each character postion is latched from the RAM into the 7-bit shift register, and outputted serially during the next 7-dot cycle so that each '1' appears as a dot. The standard ASCII characters are displayed in a 7 line by 5 dot format or font. The 7 lines are copied line by line into the first 7 lines of the 10 line character field, leaving lines 7 through 9 as vertical spacing between characters. Data bits 1 through 5 are used for characters, leaving dots 0 and 6 as spacing between adjacent characters. The keyed character then appears on the screen and the cursor is incremented to the next position.

#### Additional Symbols

An additional 2716 EPROM with pre-programmed electronic symbols can be selected instead of the ROM, so that circuit diagrams can be drawn on the screen. Each symbol in the EPROM can be 10 lines of up to 7 dots so that each character may be continuous into the next—a necessity for circuit diagrams. The EPROM is selected by typing CTL Z on the keyboard and then a key, which can be either upper or lower case. This then displays the appropriate symbol in a similar manner to an alphanumeric character. To return to alphanumerics again, another CTL Z is required from the keyboard.

Two sequences are also stored in this EPROM, at addresses 1D00H and 1E00H. When either of these are called up by the program DRAW, a circuit diagram is drawn on the screen. This is an efficient way of storing

circuit diagrams. Each circuit sequence, requires about 200 bytes, which is not a lot to cover most of the screen, much less than the 19k bytes normally required to save every dot.

Although the symbol EPROM was programmed for electronic symbols, other kinds of symbols may be programmed into this EPROM, such as mechanical symbols.

Programming this EPROM is not easy. Assuming ASCII characters are to be used to select each symbol, then the addresses  $A_6$ ,  $A_5$ ,  $A_4$  must be 100, 101, 110, 111 corresponding to ASCII codes 4XH to 7XH, where X is address  $A_3$ ,  $A_2$ ,  $A_1$ ,  $A_0$ . The 4 lines LC 3, LC 2, LC 1 and LC 0 go to address bits  $A_{10}$ ,  $A_{9}$ ,  $A_{8}$ ,  $A_{7}$ . The EPROM is selected with 00011B to  $A_{15}$ ,  $A_{14}$ ,  $A_{13}$ ,  $A_{12}$ ,  $A_{11}$ . In other words, to select the first line of character A (41H), the address would be 1841H, and for the second line 18C1H etc.

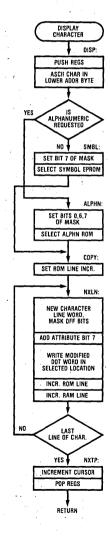


Figure 19. Displaying a Character

#### Locating the Position of a Dot

The standard DP8350 displays 80 horizontal characters for each of 24 rows, each character field comprising 10 lines of 7 dots. Thus there are  $80 \times 7$  or 560 horizontal dots and  $24 \times 10$  or 240 vertical dots in the display. Let the value of the horizontal dot position be x, where  $0 \le x$ < 560, and y be the vertical dot position, where  $0 \le y \le$ 240. Refer to Figure 20.

If the x and y values are inputted to the microprocessor, it can then compute the character position, the line number and the dot position number. First, the Row Number r is INTEGER (y/10). This then has to be multiplied by 80 to produce the ROW START number. The Column Number then has to be added to this to obtain the Character Position Number, where the Column Position c is INTEGER (x/7). The line of the row is (y-r), and the dot number is (x-c) for the computed character position.

For the 8080 microprocessor, multiplication and division of numbers is laborious and time consuming. It is therefore easier to use the program subroutine shown in Figure 21 to compute the character position, line number, and dot number. A separate subroutine then computes the dot word from the dot number. This 7-dot word is then ORed with the word already in the computed dynamic RAM location. All this can be demonstrated using the program PLOT.

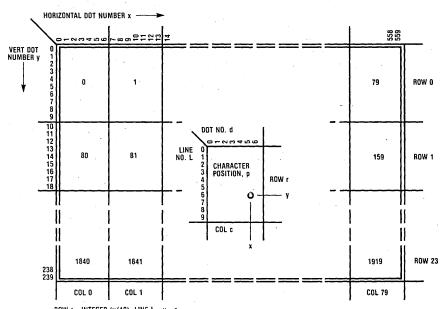
This computation takes an average of 300 µs and a maximum of 500 µs. Hence up to 3,000 dots can be plotted per second for any values of x and y to create a graphics display.

A good demonstration of the graphics capability is to connect an x-y joystick to two analog inputs of the A/D converter and by selecting the program MOVD (move dot), moving the joystick. The joystick can be moved quickly from one extreme to another and all dots on the way are displayed. This program can also use a dot as the cursor, using the joystick to select its position, and then to depress keys whenever a desired character is required at the character position of the dot.

#### **Dot Word Transfers**

With the use of the ACE, it is possible to unload the contents of the RAM into either an identical terminal to copy the display, or to store it in a main computer. It can then be recalled from the computer at a later date and re-loaded into the RAM to be displayed. Or if desired, sections of the display can be transferred. Copying from or to the display can be fast, because 7 dots are read or written at a time. An example of this is to use the programs SAVE and LOAD. A section of the display (such as a circuit diagram) can be saved in the back-up RAM, and then loaded back on to the display in a different area. The diagram appears almost instantly.

This extra 13k bytes of back-up RAM can also be used as additional memory for in system emulation of programs, or for powerful computing capability for graphics calculations.



ROW r= integer (y/10), line L=y-r column c= integer (x/7), dot number d=x-c dot at location x,y is in character position p , line L , dot no. d, where p=80r+c

Figure 20. CRT Display/8350 Character Address Positions

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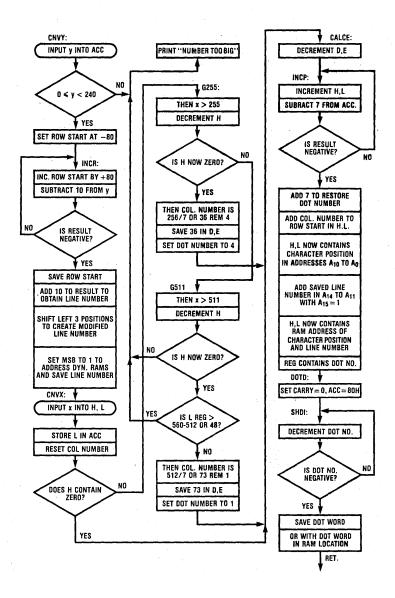


Figure 21. Flow Chart to Add Dot x, y to Display

#### **Graphics Programs**

To perform various graphics functions it was decided to select the necessary software with four letter program labels, followed by a carriage return. As long as the label derived starts at the first column of a row, the program requested is called up and executed. Some programs request information from the operator. PLOT is an example of this, where the values Y1 and X1 are requested by the display. The user types in the desired values in normal decimal, signifying the end of the number with a carriage return. After both y and x have been entered, the program continues, in this case plotting a dot at Y1, X1.

#### Conversion of Entered Decimal Numbers

The conversion of the decimal numbers entered and saved in the Input Number registers, is performed by the subroutine ENTR. First the last decimal number entered (obviously units) is tested for ASCII number units and then saved. The second number (tens) if entered, is then tested and decremented until 0 is reached, and each decrement, 10 is added to the total number. Then the third number (hundreds) is tested and decremented to 0, each time 100 is added to the total. At the end of the conversion, H, L register contains the total number in binary. This is then saved in the respective register.

# Conversion of 2 Hexadecimal Characters to an 8-Bit Word

This subroutine takes 2 ASCII characters each in the range 0 to 9, A to F, and converts them to a binary word. First, the 3 ASCII code bits are masked off the number first entered. This is shifted left 4 times and added to the masked off 4 bits of the second number entered. This 8-bit word is now 7 dots plus one attribute bit. With this method, it is easy to write/read words quickly on to the display, in the selected location. This can be demonstrated with the program DMPI (dump-in) as in the next two sections.

#### **Display Loading**

The starting address is first entered (anywhere from 8000 H to FDFFH) by keying in the first two hex numbers when requested by B= (byte), no carriage return, then the last two hex numbers. This is repeated for the end address. The bytes are then entered 2 ASCII characters at a time. If the addresses are between 8000H and CFFFH, the words will appear on the display. For example, 7F will appear as 7 dots, or 83 will appears as the 2 right-hand dots with attribute. In this way a picture can be loaded on to the display.

#### Use of Back-up RAM

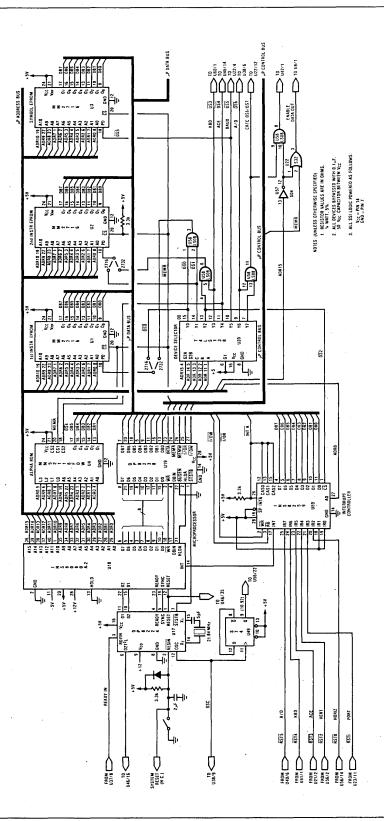
If the DMPI addresses are between D000H and FDFFH, the information is stored in the back-up RAM. This is useful for in-system emulation, for example. By calling up the program EXT0 (External 0), if a program has previously been loaded in the back-up RAM, starting at address D000H, this program will then be executed after EXT0, carriage return. Another use of this section of RAM is the storage of different sequences of circuit diagrams other than those in the symbol EPROM. The program DRAW can then call up the starting address.

#### Additional Software

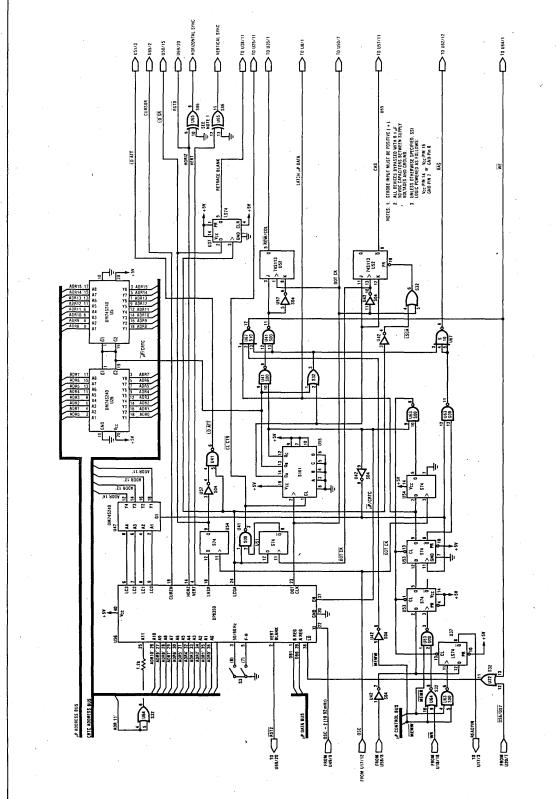
The power and versatility of this system is easily demonstrated with the existing software. This can be added to as required with new software, calling up existing subroutines where possible. Up to 4k bytes of additional software can be incorporated without any hardware modifications (other than moving two links to select 2732s instead of 2716s).

#### Conclusion

So using all National Semiconductor ICs, at a cost of a few hundred dollars, the hardware for an intelligent terminal with full graphics capability can be fitted on one BLC80/SBC80 size card. The design is easily expandable to systems requiring color. The biggest modification is to the memory; instead of one bit per dot, 3 bits are required for blue, green, and red, to give 8 possible combinations per dot. A small number of extra logic ICs are required, as are minor additions to the software. To select the color, a CTL key can be used followed by the code for the color. This color will then be written until changed by the CTL key. A different CTL key followed by a number could previously have set the background.



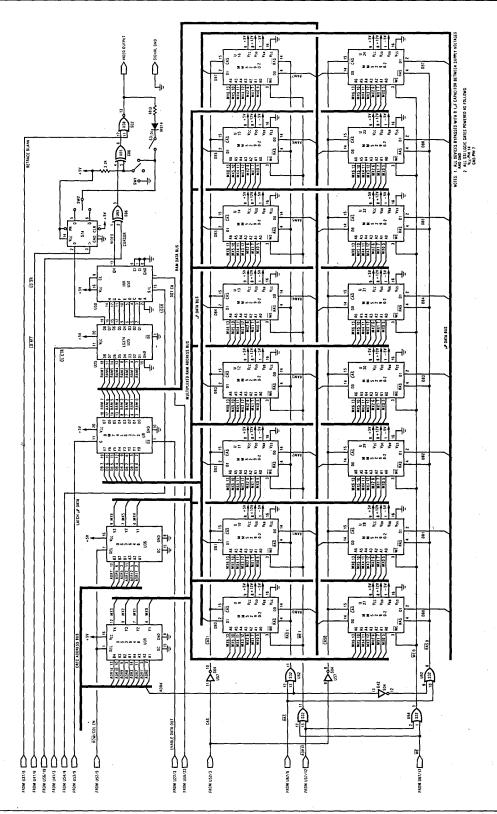
DP8350/INS8080 Full Graphics Video Terminal System — CPU, EPROM and Interrupt Block

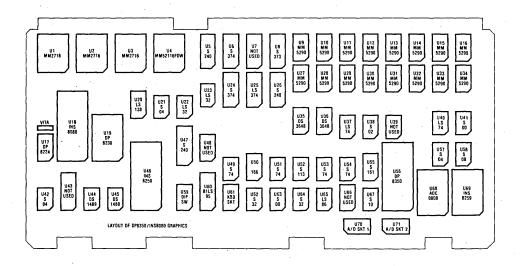


DP8350/INS8080 Full Graphics Video Terminal System — Memory Control

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DP8350/INS8080 Full Graphics Video Terminal System — Memory/Video





Layout of DP8350/INS8080 Graphics

### Present Capabilities of Alphanumerics/Graphics System

#### **Dumb Terminal Functions**

** All 128 A	ASCII CI	naracters	Displayable
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- \*\* Space
- \*\* Carriage Return

** Horizontal Tab	(→) or (CTL L)
** Backspace	 (←) or (CTL H)

- \*\* Linefeed (‡) or (CTL I)
- \*\* Vertical Tab (†) or (CTL K)
- \*\* Select/Deselect Attribute (CTL R) with SW-1 or S-3
- \*\* Tab 8 Spaces (Tab) (CTL T)

  \*\* Clear Cursor Row (CTL X)

  \*\* Clear Row Right of Cursor (CTL S)
- \*\* Initialize System (CTL A)
- \*\* Select Baud Rate from 110 to 19,200 Using S-1 and CTL E
- \*\* Scrolling Upwards

#### Non-Standard Character/Symbol Selection

\*\* By selecting CTL Z, symbols can be displayed for each key of the keyboard, including shifted and control keys. Also can deselect back to standard ASCII characters with CTL Z.

#### **Graphics Programs**

- \*CLSC: Clears screen only, leaving 13k back-up RAM unaffected.
- \*LIST: Lists all graphics programs.
- \*PLOT: Plots a dot at X, Y. X is the number of horizontal dot positions from the left of screen, from 0 to  $7\times80$  for the 8350, i.e.,  $0 \le x \le 559$ . Y is the number of vertical dots from the top of the screen, from 0 to  $10\times24$ , i.e,  $\le 0 \le y$  239. The operator keys in the decimal values of Y and then X when requested by the display.
- \*VLIN: Draws a vertical line between Y1 and Y2 at X. These values are entered decimally by keyboard when requested by the display.
- \*HLIN: Draws a horizontal line between X1 and X2 at Y1. These values are entered decimally by keyboard when requested by the display.
- \*RECT: Draws a rectangle linking lines X1, X2, Y1, and Y2
- \*PONG: Bounces a dot around the screen between the four walls of the display.
- \*DRAW: Draws a diagram on the screen from a sequence of operations saved in ASCII code in memory. The START address of the sequence is determined by the first four hexadecimal characters entered on the keyboard. The address 1D00H selects a DC voltage restoring circuit sequence located in the symbol EPROM. Address 1E00H selects a logic circuit and waveforms. Test sequences can be loaded into back-up RAM using program 'DMPI' at the starting and end address entered. This start address is then called up by 'DRAW.' The end address must contain 0 (zero).
- \*SAVE: Saves in the back-up RAM a section of display contained within rows R1 to R2, and columns C1 to C2. These values are entered decimally by keyboard when requested by display. The start address in the back-up RAM is selected by the first four hexadecimal characters entered on the keyboard.
- \*LOAD: Loads from the back-up RAM to a section of display bounded by R1, R2, C1, C2. These values are entered decimally by keyboard when requested by the display. The back-up RAM start address is selected as in SAVE.
- \*DOTS: Plots N dots on any line Y1 at postions X1, Y1; . . . XN, Y1; and then any new line entered in decimal by the operator. Ends the program by entering 0 (zero) when the next Y1 is requested.

- \*MOVD: Uses the 8-channel 8-bit A/D converter to monitor the voltages on a X-Y joystick, an inhibit-draw switch, and an exit-program switch. In the DRAW mode consecutive dots are plotted to create a picture as described by the movement of the joystick. All these input signals are connected to the first A/D socket. In the inhibit DRAW mode the dot is moved around by the joystick as a cursor, and by keying in from the keyboard the desired charcter, this character will appear in the character field of the dot. This moving dot can be used to erase existing dots, or erase characters by keying 'SPACE' in the desired position. To exit the program, set the EXIT program switch in EXIT-DRAW mode with the Inhibit-Draw Switch in INHIBIT.
- \*WAVE: Uses the A/D converter to create waveforms on the screen when the signals are connected to the second A/D socket.
- \*DMPO: Unloads any part of RAM to an external system starting at an address keyed in by the operator in hexadecimal characters (four) and ending at another similarly entered address. The RAM is unloaded 7 dots at a time per line of character and converted to two ASCII characters and then transmitted serially.
- \*DMPI: Loads any part of RAM from an external source (or the keyboard) starting at an address selected by the first four hexadecimal characters entered on the keyboard and ending at another similarly entered address. The RAM is loaded 7 dots at a time per line of character, keyed in by two hexadecimal characters, for each word. The addresses selected can be display addresses 8000H to CFFFH or back-up RAM addresses D000 to FFFFH (warning: FE00H upwards are registers and FFFFH downwards are stack). Thus a complete picture could be loaded on to the display. Alternately a program could be loaded into back-up RAM at EXT0 (D000H), EXT1 (D800H), EXT2 (E000H), or EXT3 (F000H), the characters 'EXTn' can then be typed in on the keyboard and this will then select the instructions beginning at address EXTn. Thus in-system emulation is easily accomplished.
- \*EXTO: Executes a program beginning at RAM address D000H. The program must previously have been entered using DMPI selecting D000H as the starting address.

As EXT0 but starts at D800H.

\*EXT2: As EXT0 but starts at E000H. \*EXT3: As EXT0 but starts at F000H.

\*EXT1:

# Software Design for a High Speed (38.4 kbaud) Data Terminal

National Semiconductor Application Note 270 Wong Hee Nick Samaras February 1982



#### INTRODUCTION

This application note describes a high speed CRT terminal designed around the DP8350 CRT controller and the INS8080 microprocessor. The hardware is a modified version of the circuit described in Application Note AN-199. The software was redesigned and optimized for terminal speed and function. In its present form it is upwards compatible with the Hazeltine 1500 video terminal and has a limited graphics capability. Furthermore, it is able to communicate with a host computer via an RS-232 port, at 38.4 kbaud, without using fill-in characters or handshaking. One 2k by 8 EPROM contains all the software required to implement the terminal. An optional EPROM can be used to add features such as menu display or to transform the terminal into a calculator (in the local mode). The absence of the second EPROM does not affect the operation of the terminal as the software checks for its presence.

#### **DATA TERMINAL FEATURES**

- Modes: remote/local
- Limited graphics
- Window scrolling
- Line transmitting and local editing
- Hazeltine 1500 compatible\*
- Video display: two pages, 24 x 80 characters/page
- Upper/lower case
- Scrolling plus screen roll up/roll down
- Cursor: blinking (two rates)
- Line, character insert/delete
- Attributes: dual intensity/inverse video
- Full duplex RS-232 port; 110-38400 baud
- Keyboard input: 7-bit parallel
- Full cursor control and addressing
- Cursor enable/disable
- Single board (BLC/SBC) compatible design

#### **UNIQUE FEATURES**

**Graphics Capability:** The graphics capability of this terminal, although limited by the number of symbols (34), proves to be very helpful. Typical uses include digital waveform generation (e.g., logic analyzer display), and graph oriented displays such as histograms. A graphics menu is available in the local mode. Entering  $1Q^{\dagger}$  from the keyboard will result in a two line menu display. Line 23 displays upper and lower case characters, while line 24 displays the corresponding graphics symbols (see *Figure 3*). In local, entering 1B will switch the terminal to the graphics mode; the ESC key can be used to exit. In remote mode, the format requirements for graphics display generation are summarized by the flowchart shown at the bottom of this page.

The same flowchart can be used in local, if the "lead-in" †† block is omitted.

Typical transmission sequences are:

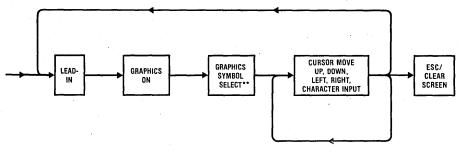
7E, 02, 42, 10, 1B 7E, 02, 63, 10, 10, 10,...,10, 1B

7E, 02, 42, 8, 8, 8, 4A, 7E, 0C, 7E, 0C, 1B

All the graphics symbols, along with the upper and lower case characters, are coded into one 2716 EPROM. As a result, both the character set and the graphics symbols may be customized. The total number of available fonts is 128. The field on each displayed character is 7 rows by 10 columns. The alphanumeric symbols occupy a 5 by 7 subfield typically, except for those requiring descenders; they occupy a 5 by 9 section, while the graphics symbols utilize the whole 7 by 10 field.

**Transmit:** The data terminal can transmit one line of text upon receipt of the 14H code from the keyboard in local mode. Alternately, the host CPU can request transmission by sending 14H prefixed by the 7E lead-in code.

<sup>&</sup>lt;sup>††</sup>Lead-in code: 7E.



<sup>\* \*</sup>Includes the ASCII characters A-Q, a-q, space and DEL.

<sup>\*</sup>The majority of the software written for the Hazeltine 1500 will run with no modification. However, there are differences.

<sup>&</sup>lt;sup>†</sup>Note that 1 indicates a control key entry.

The same function can be used in a relatively unconventional way when programming in BASIC. The majority of BASIC interpreters used in small business systems or home computers incorporate a line-oriented editor, almost adequate for most of the tasks they have to perform. The basic problem with such editors is that they cannot change the flow of the program easily. In other words they cannot change line numbers. This is a shortcoming, as it is both annoying and tedious having to retype segments of text in order to change the program flow, just because the editor cannot handle altering line numbers only.

This terminal offers an efficient solution to this problem. Simply stated, it allows changing line numbers only. Here is a brief description of a typical sequence leading to text and/or line number modification. Let us assume that a BASIC interpreter is used and that the program that needs to be changed is in memory. Using the list command, the program lines to be modified can be displayed. Now, while in the Command Mode of BASIC, the terminal is switched to local. The user has effectively at his disposal a screenoriented editor. The cursor can be moved about and text changed as desired; that, of course, includes line numbers. When the editing is completed, the user positions the cursor on the line that was altered and types 1T. In response, the cursor scans the line, inverting the attributes. At the same time the line is transmitted to the host CPU in the same order as it was scanned, from left to right. Attribute inversion serves as feedback to the user. After the last character of each line has been transmitted, the cursor returns to the beginning of the following line. As a result, consecutive 1T keyboard entries transmit successive lines. Thus, altering the flow of a BASIC program involves entering the local mode, changing line numbers, transmitting the modified program lines, and switching back to on-line operation. All this can be accomplished at a fraction of the time usually required otherwise. Finally, entering similar lines of text such as the ones found in "PRINT" statements, can be accomplished easily by switching to local, typing the first line and transmitting it; then moving the cursor up one line, changing the line number along with parts of the text that are different, retransmitting the line, and so on. In this way the user can create a long program segment while operating repetitively on one line.

Insert/Delete with Range: This is a rather unusual function that can assist in generating psuedo "screen window" effects. Specifically, a pre-selected number of display lines can scroll while the rest of the display remains fixed. Each "window" is defined as N lines by 80 characters, where: 1 < N < 48, counting from the current cursor location to the end of page. The brief BASIC program that follows demonstrates the use of this function. In this example the display lines 1 through 4, and 19 through 24 remain "frozen". The message (100 lines long) is displayed on lines 5 through 18, demonstrating the scrolling of a section of the display.

- 100 PRINT CHR\$ (&H7E) + CHR\$ (&H11) + " d";
- 110 FOR I = 1 TO 100
- 120 PRINT CHR\$ (&H7E) + CHR\$ (&H1D) + CHR\$ (&H49) + CHR\$ (12);
- 130 PRINT, "WINDOW SCROLLING LINE:", I, CHR\$ (&H0D);
- 140 NEXT I

80 Character Software FIFO: This is one of the key items that allows terminal communication at 38.4 kbaud without handshaking. An 80 character first-in, first-out software buffer is used. The incoming characters are stored temporarily in this buffer, while the microprocessor is servicing interrupts. As time becomes available, the characters are retrieved from the FIFO and processed. That includes performing a terminal function or moving an ASCII character to the video memory. The software allows for a large number of concurrent service requests such as row start, keyboard, as well as multiple ACE interrupts.

Fast Service Routine for Row Start Interrupt: Conventional row start address look-up and loading are not done during the row start interrupt time; instead, a simple row counting routine is used. The terminal count (a software counter) generates a triggering signal for video RAM wraparound address loading. The use of this technique improves the system throughput substantially. Cursor and Top of the Page address loading (i.e., writing to the appropriate DP8350's registers) is done during the vertical retrace interval.

**Keyboard Controlled Mode Selection:** The operating mode of the terminal can be selected from the keyboard. To aid the user in identifying which mode the terminal is in, two cursor blinking rates are used. The low rate indicates remote mode; a high rate indicates local.

Other functions that can be selected from the keyboard are:

- 1) Upper/lower case. The default mode upon power up is determined by reading the SW3 switch setting.
- 2) Next page. A software switch that selects for display page one or two.

**Read Cursor:** In the local mode the present cursor location can be displayed on line 24, columns 79–80. For example, if the cursor is located on line 8, column 66, entering 1 E from the keyboard will result in a display of "Ag" at the bottom right hand corner of the screen. This can save time in looking up the ASCII equivalent codes of the X, Y cursor coordinates to be used in cursor addressing. (Note that, 1 = 100

The following is an example of how this could be used in a BASIC program.

PRINT CHR\$ (&H7E) + CHR\$ (&H11) + "Ag"

Upon execution of the above statement, the cursor will move to line 8, column 66.

Menu Display: In the local mode the user has access to a menu display that summarizes the terminal's functions, along with the corresponding control codes (see Figure 1). This feature is optional and resides in EPROM #2. The important thing to note is that various kinds of menu/HELP displays can be implemented easily in this fashion. This function can be accessed from the keyboard. Alternately, a dedicated HELP key (that generates the 1D code) can be used.

#### **ACKNOWLEDGEMENTS**

We would like to thank Barry Siegel for his invaluable guidance and support. Also we would like to thank Ron Christopherson for contributing so much of his time to this project.

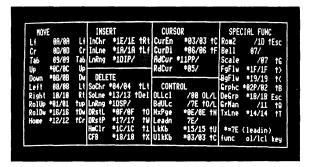


FIGURE 1. Sample Menu Display

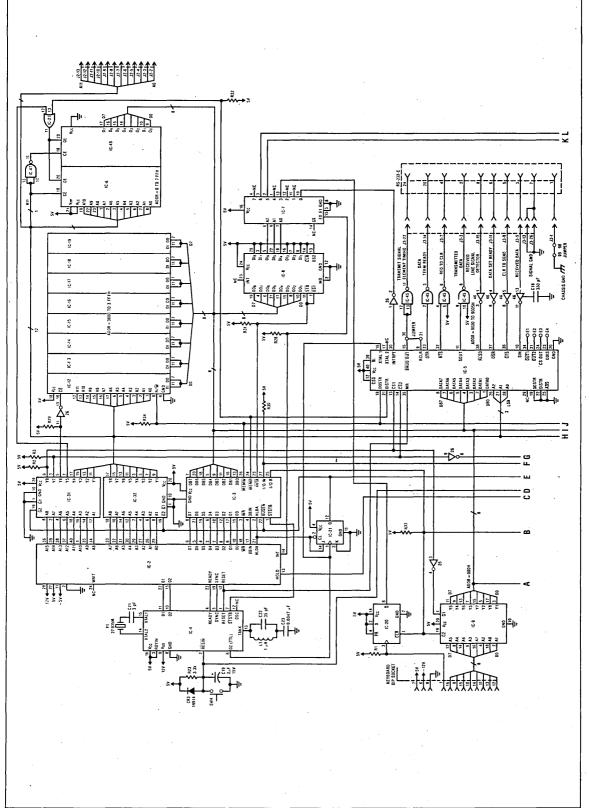
#### **Character Generator Fonts**

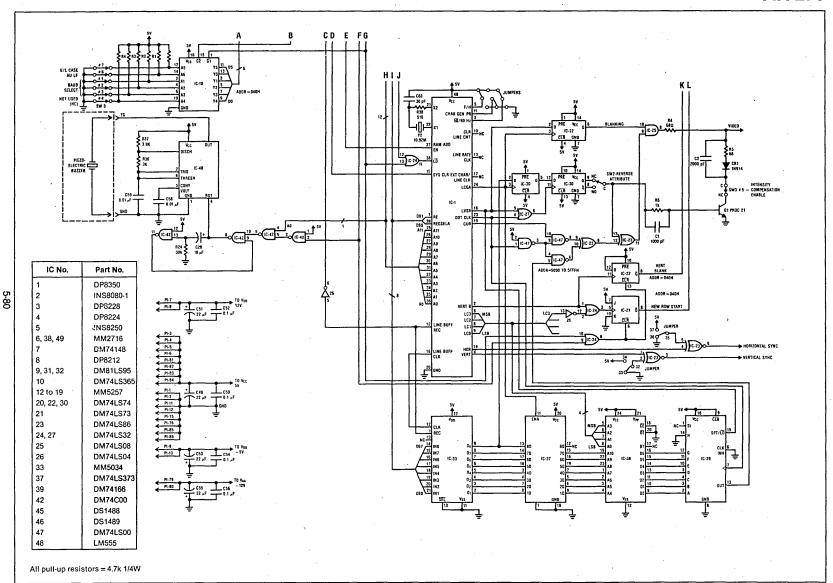
ADDR			
00- 0F			** * 0  *** ** 1  *** *** 2  **** ** 7  **** ** ** 7  *** ** ** 8
10- 1F		0	• • • 0 • • 1 • • • 2 • • • 2 • • • 3 • • • 5 • 7 • • 6 • 7
20- 2F			0 1 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2
30- 3F		0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	* * * * * * * * * * * * * * * * * * *
40- 4F			0 1 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2
50- 5F		0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	0 1 2 2 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3
60- 6F		• • • • • • • • • • • • • • • • • • •	 0 2 2 2 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3
70- 7F		0 1 2 3 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5	 

FIGURE 2. Sample Character Font

FIGURE 3. Graphics Menu Shown at the Bottom of the Screen

A complete listing of the software for the "High Speed Data Terminal" can be found on pages 5-84 through 5-103. A HEX dump of the character generator set is included on pages 5-82 and 5-83 and the schematic diagram on pages 5-79 and 5-80.





#### **CONTROL FUNCTIONS SUMMARY**

Functions	On-Line / Local	Remarks
Cursor Move/Control		
Line feed	0A / 0A	
Carriage return	0D / 0D	
Tab	09 / 09	•
Cursor up	7E, 0C / 0C	
Cursor down	7E, 0B / 0B	
Cursor left	08 / 08	
Cursor right	10 / 10	
Home	7E, 12 / 12	
Home and clear	7E, 1C / 1C	
Enable cursor	7E, 03 / 03	
Disable cursor	7E, 06 / 06	
Address cursor	7E, 11, X, Y /	Remote only
Read cursor	7E, 05 / 05	
Insert		
Character insert	7E, 1E / 1E	
Line insert	7E, 1A / 1A	
Line insert with range	7E, 1D,49,Y	Pomoto only
Line insert with range	7 E, 10,49, f	Remote only
Delete		
Character strip	7E, 04 / 04	
Character delete	7F / 7F	
Line delete	7E, 13 / 13	
Line delete with range	7E, 1D,53,Y /	Remote only
Clear to end of line	7E, 0F / 0F	
Clear to end of page	7E, 17 / 17	
Miscellaneous		
Local/remote	/ 00	Local only
Upper/lower case	/ 7E	Local only
Next page	7E, 0E / 0E	
Keyboard lock	7E, 15 / 15	
Keyboard unlock	7E, 03 / 03	•
Bell	07 /	Remote only
Special Functions		
Function menu	/ 1D	A summary of available functions and their corresponding
O	77 00 1 00	codes (local mode only).
Graphics on	7E, 02 / 02	Enter graphics mode.
Graphics off	7E, 1B / 1B	Exit graphics mode.
Graphics menu	/ <b>11</b>	Line 23 displays upper and lower case characters and line 24 the corresponding graphics symbols (local).
Line transmit	7E, 14 / 14	Transmits the cursor line and inverts its attributes.
Foreground follows	7E, 1F / 1F	
Background follows	7E, 19 / 19	
Clear foreground	7E, 18 / 18	
Scale	/. 07	The line above the cursor becomes a scale (1-80). This is an aid for graphics and text alignment (local).
Roll up	7E, 01 / 01	an are for grapines and text angiment (local).
Roll down	7E, 16 / 16	
1	, 10 / 10	
		4

## CHARACTER GENERATOR HEX DUMP

ADDR	0	1	2	3	4	5	6	7	8	9	A	В	С	D	Е	F
0 10 20 30 40 50 70 80 70 80 60 70 60 70 80 60 70	14 0 10 14 0 0 10 10 10 10 10 10 10 10 10 10 10 10	14 0 10 8 0 0 10 10 10 10 10 10 10 10 10 10 10 10	14 0 10 14 0 0 10 10 10 10 10 10 7	14 7CC 18 55 7FC 1F 7F 1F 7F 1F 28	14 7C 114 2A 7F 7C 1F 7F 7F 7F 1F C 18	14 7CC 8 55 7CC 1F 7C 1F 7F 7F 1F 1B C	14 1C 1C 14 0 0 0 0 0 1C 1C 1C 1C 1C 1C	14 1C 1C 8 0 0 0 0 1C 1C 1C 1C 70 7	14 10 10 14 00 00 00 10 10 10 10 10 10 10 10 10 10	14 1C 1C 8 0 0 0 0 1C 1C 1C 1C 1C 1C	0000000000000000	0000000000000000	000000000000000	00000000000000000	0000000000000000	0000000000000000
ADDR	0	1	2	3	-4 	5	6	7	B	9	_A	В	С	D	E	F
100 110 120 130 140 150 160 170 180 190 100 100 100 1F0	008000888880010	0080008888800000	BOBUBOBBBBBBOON O	1C 08210 8888 800410	108 2577 F77 F77 F88 4	3882C 0000888888 5	38 8 2 8 0 0 0 0 3 8 8 8 8 1 4 6	3683000008888822 7	оввооооооввввво 0	08800000088888 41 9	000000000000000	0000000000000	00000000000000000000	000000000000000	000000000000000 E	00000000000000 F
200					- <del>-</del>			- <u>-</u>			- <u></u> -					
210 220 230 240 250 260 270 280 290 2A0 2B0 2C0 2D0 2E0	0 4 0 0 0 0 0 0 0 0 0 0	8408388880000	B 14 14 12 32 14 10 10 4 24 8 0 0 0	8 0 3E 8 4 14 0 20 2 10 8 0 0 0 4	8 0 14 10 8 18 0 20 24 3E 0 3E 0 8	B 0 3E A 10 20 20 2 B B 0 0 0 10	0 0 14 3C 26 24 0 10 4 0 8 8 0 0 20	8 0 0 8 2 1 4 0 8 8 0 0 8 0 8 0 0 8 0 0 0 0 0 0 0 0	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	00000000000000	00000000000000	0000000000000	0000000000000	00000000000000	0000000000000	0000000000000
ADDR	0	1	5	3	4	5	6	7	B	9	Α	B	С	D	E	F
300 310 320 330 340 350 360 370 380 390 340 360 360 360 360 360 360	000000000000000	1C B 1C 3E 1C 3E 1C 1C 0 0 4 0 10	2 1 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	26 8 24 14 30 22 28 8 10 8 10 8	2A 8 C C 24 2 C 1E 0 C C 24 1C E C C C C C C C C C C C C C C C C C	32 8 10 2 2 2 2 2 0 0 1 3 4 8	2 0 2 4 2 2 8 2 8 8 8 0 8 0	1C 3E 1C 4 1C 1C 1C 0 8 1C 0 8	000000000000000000000000000000000000000	000000000000000	000000000000000	00000000000000	00000000000000	00000000000000	00000000000000	000000000000000

			CHA	ARAC	TER	GENE	RAT	OR H	EX DI	JMP (	Cont	inued	i) ·			
ADDR	0	1	5	3	4	5	6	7	8	9	Α	В	С	D	E	F
400 410 420 430 440 450 450 470 480 490 480 490 4E0 4E0 4F0	00000000000000000	10 10 10 10 10 10 10 10 10 10 10 10 10 1		22222222228422222	2502200E 400AA2	222222222842222 222222228422222	022220022 440222	1E 23CCC3E 1CCE 1CCE 1E 2CC 1E 2CC 1E 2CC 1E 2CC 1E 2CC 1CCE 1CCE	000000000000000	0000000000000000	0000000000000000	00000000000000	000000000000000000000000000000000000000	000000000000000000000000000000000000000	0000000000000000E	00000000000000 F
ADDR		3c	 22	3		5 	6  20	 20			- <del></del>	<u>-</u>	<del>-</del>		<u>-</u>	
500 510 520 530 540 550 560 570 580 580 580 500 500 550 550	00000000000000	10013222222E23B0	2222822222282818 222282222 22228222 2222822 2222822 222282 2228282 2282 2228 22282 22282 2282 20282 20282 20282 20282 20282 20282 20282 20282 20282 20282 20	2220 2221 124 810 820 10 10 10 10 10	30 20 10 10 10 10 10 10 10 10 10 10 10 10 10	20AB 28214AA 14B10 84BB10	2442 2 8 2 8 2 8 2 8 8 8	1A2C B1C B14 2B BE BBE BBE BBE BBE BBE BBE BBE BBE B	00000000000000	00000000000000	000000000000000	00000000000000	000000000000000	000000000000000	000000000000000	000000000000000
ADDR '	. 0	1	2	3	4	5	6	7	B	9	Α	В	. с	D	Ε.	F
600 610 620 630 640 650 660 670 680 690 640 6E0 6E0 6F0	100000000000000	8 0 20 0 20 0 20 8 4 10 18 0 0 0	4 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	0 1C 20 1E 20 1E 20 18 4 12 8 36 3C 1C	0232122C 122C 8414 8222	0 12202E 8228 4 18 8222	0 22 20 22 0 8 1 E 2 8 2 4 4 8 2 2 2 2 2 2 2 2 2 2 2 2 2 2	0 1E 3C 1E 1C 8 22 1C 18 12 1C 22 1C 22 1C 22 1C 22 1C 22 1C 22 1C 22 1C 24 1C 24 1C 26 1C 1C 26 1C 26 1C 1C 26 1C 26 1C 1C 1C 26 1C 1C 1C 1C 1C 1C 1C 1C 1C 1C 1C 1C 1C	000000000000000000000000000000000000000	0000000000000000	000000000000000	0000000000000000	00000000000000	0000000000000000	000000000000000000000000000000000000000	000000000000000
ADDR	0	1	2 	3	4	5	6	7 	8	9	Α	В	С	D	E	F
700 710 720 730 740 750 760 770 780 780 780 780 700 700 700 700 70	00000000000000000	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 1 0	000080000088803E	3C 116 116 110 122 122 122 122 130 14 176	222180 8 222142 14240 0 202	22 10 10 8 22 24 8 22 8 20 10 8 4 7 7 2	3C 1E 10 2 8 22 14 2A 14 1E 10 8 8 8 0 36	20 20 10 30 4 10 8 14 22 3E 8 8 8 0 3E	20 20 00 00 00 00 00 00 00 00 00 00 00 0	000000000000000	000000000000000	000000000000000	00000000000000	000000000000000	00000000000000	000000000000000

```
STARPLEX MACRO-ASSEMBLER V2. 0
                                             PACE
                                                      1
CRT801
                                    TITLE CRT801
                           /May 1980
  0000
                           ASEG
                           ORG
                                    00000h
                           :constants
  000A
                           LF
                                    equ
                                             OAh
  OOOD
                           CR
                                    equ
                                             ODh
  0020
                           SPC
                                    equ
                                             020h
  007E
                           LINC
                                    equ
                                             07Eh
                                                      ; leadin code
  0060
                           RWRG
                                             low RR48-low RR1+2
                                    equ
  0003
                           KULCDE
                                                      ; kbd unlock code
                                    equ
                                             03h
                           ; I/O ports
  0080
                           KBDPRT
                                    eau
                                             080h
                                                      ; keyboard
  0040
                           ROWPRT
                                             040h
                                    equ
                                                      ;row interrupt
                                                      vertical interrupt
  0040
                           VERPRE
                                    equ
                                             OAOh
  0040
                           SETSW
                                    equ
                                             040h
                                                      ; baud_sel, autolf, u/lcase
  0002
                           LCLIND
                                    equ
                                                      ; local indicator
  0001
                           BELPRT
                                    equ
                                                      ;bell
                           ace
  9000
                           ACEDTA
                                             09000h
                                    equ
                                                     idata
                                             ACEDTA+1; interrupt mask
  9001
                           ACEITR
                                    equ
  9003
                           ACECTL
                                             ACEDTA+3; control
                                    equ
  9005
                           ACESTU
                                    equ
                                             ACEDTA+5; transmit status
                           ram a
                                   signment
                                             O3FFFh ; first row reg pair
  3FFF
                           FROWH
                                    equ
  3FFE
                           FROW
                                             FROWh-1;
                                    equ
                                             FROWh-2 ; last row reg pair
  3FFD
                           LROWH
                                    equ
  3FFC
                           LROW
                                             FROWN-3;
                                    equ
  3FFB
                           CROWH
                                             FROWh-4 ; cursor row reg pair
                                    equ
  3FFA
                           CROW
                                             FROWN-5 ;
                                    eau
  3FF9
                           CURH
                                             CROW-1
                                    equ
                                                     ; cursor reg pair
  3FF8
                                             CROW-2
                           CUR
                                    equ
  3FF7
                           TOPH
                                    equ
                                             CUR-1
                                                      ; top of page reg pair
  3FFA
                           TOP
                                    equ
                                             CUR-2
  3FF5
                           NRW
                                    equ
                                             TOP-1
                                                      ; row counter
  3FF4
                           VCALEN
                                    equ
                                             TOP-2
                                                      ;vert calc routine enable
  3FF3
                           GSYMBL
                                             VCALEN-1; graphics symbol
                                    equ
  3FF2
                           AULF
                                             GSYMBL-1; auto linefeed, O=auto 1f
                                    eav
  3FF1
                           LOCLM
                                             AULF-1
                                                     ; local mode, O=remote
                                    eav
  3FF0
                           ULCASE
                                             AULF-2
                                                     ; upper/lower case, 0=lower
                                    equ
                                                    graphic enable. O=disable keyboard lock. O=unlock
                                             AULF-3
  3FEF
                           GECNTI
                                    equ
  3FEE
                           KBDL-CK
                                             AULF-4
                                    equ
                                             KBDLCK-1; cursor blink rate cntl
  3FED
                           RTECTL
                                    equ
  3FEC
                           CUREN
                                    equ
                                             KBDLCK-2; cursor enable, 0=off
  3FEB
                           CURTMR
                                             KBDLCK-3; cursor blinking timer
                                    equ
                           FFWCT
                                             KBDLCK-4; ace fifo word count
  3FEA
                                    eqυ
  3FE9
                           LEADIN
                                             KBDLCK-5; leadin mode, O=no leadin
                                    equ
  3FE8
                           ICMD
                                             KBDLCK-6; insert char mode, 0=insert
                                    eau
  3FE7
                           CPYCTL
                                             ICMD-1 ; row copy direction cntl
                                    eav
                                             CPYCTL-1; fifo write pointer
  3FE6
                           FFWRT
                                    equ
                                             CPYCTL-2; fifo read pointer
  3FF5
                           FFRD
                                    equ
                                             FFRD
  3FF5
                                                     ; stack
                                                                   3FE4h down
                           STK
                                    equ
                           LINP
                                             FFEND+4 ; leadin parameter storage
  3FA3
                                    equ
  3FA2
                           LINWCT
                                    equ
                                             FFEND+3 ; leadin word count
 STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
CRT801
                                             FFEND+2 :leadin func jmp addr high
  3FA1
                           LINFH
                                    equ
  3FA0
                                             FFEND+1 ; leadin func jmp addr low
O3F9Fh ;ace fifo end
                           LINE
                                    eau
  3F9F
                           FFEND
                                    equ
  3F50
                                             03F50h
                           FFSTRT
                                    equ
                                                      ;ace fifo start 3F50/3F9Fh
  3F20
                           FBC
                                    equ
                                             03F20h
                                                      ;fore/background cntl
                           DMYROW
                                                     dummy row 3F00/3F4Fh
  3F00
                                             03F00h
                                    equ
  3780
                           FCHR2
                                    equ
                                             03780h
                           ; INTERRUPTS
  0000
                                   DI
           F3
                           START:
                                                               ; restart O
  0001
           21'3F00
                                    LXI
                                             H, DMYROW
                                                               ; clr non video ram
           F9
                                    SPHL
  0004
           C3 00E2
                                    JMP
                                             INIT
  0005
                           row interrupt
  0008
           F5
                           ROW:
                                    PUSH
                                             PSW
                                                               restart 1
  0009
           oc
                                    INR
  000A
           C2 0066
                                    JNZ
                                             NOWRAP
                                                               ino wrap arroud
  OOOD
           C3 0061
                                    JMP
                                             VRWRAP
                                                               ido wrap arround
                           vertical interrupt
  0010
                                    PUSH
           E5
                                                               restart 2
                           VERT:
                                             н
           21 3FF5
                                             H, NRW
                                    LXI
  0011
  0014
           4E
                                    MOV
                                             C.M
                                                               ; load NRW
  0015
           C3 07AE
                                    JMP
                                             UTSUR
```

```
; ace duplicate interrupt
0018
         C3 0038
                       ACEDUP: JMP
                                       ACE
                                                       ;restart 3
                       (FUNCTION) disable cursor
 001B
         21 3FEC
                       DICUR: LXI
                                       H, CUREN
                                                        ; disable cursor
 001E
                               MOV
                                                        ; a=0
001F
         C9
                               RET
                       ; keyboard interrupt
                               PUSH
0020
         E5
                                                        restart 4
0021
         F5
                               PUSH
                                       PSW
         21 SFEE
                                       H, KBDLCK
0022
                               IXI
                                                        keyboard lock cntl
         C3 02C9
                                       KBDINT
0025
                               JMP
                       ; -----
                       ;row duplicate interrupt
0028
         F5
                       ROWDP:
                               PUSH
                                       PSW
                                                        restart 5
0029
         ОС
                               INR
                                       С
 002A
         C2 0066
                               JNZ
                                       NOWRAP
 002D
         C3 0061
                               JMP
                                       VRWRAP
                       vertical duplicate interrupt
0030
         C3 0010
                       VERTDP: JMP
                                       VERT
                                                        irestart A
                       TABSTP: XCHO
0033
         FR
                                                        ; hl=crow
                               POP
0034
                                       D
         D1
                                                        remove call
0035
         D1
                               POP
                                       D
0036
         73
                               MOV
                                       M, E
                                                        return org crow
0037
         C9
                               RET
                       PAGE
STARPLEX MACRO-ASSEMBLER V2. 0
                                       PAGE
                                                3
0038
                       ; ACE INTERRUPT
                       : ***********
                               PUSH
0038
         E5
                       ACF.
                                       н
0039
         F5
                               PUSH
                                       PSW
AEOO
         21 3FEB
                               LXI
                                       H, CURTMR
 0030
         D5
                               PUSH
                                       D
003E
         AF
                               XRA
                                       Α
003F
         77
                               MOV
                                       M, A
                                               ;reset cursor timer
0040
                               DCX
                                               FFWCT
         2B
                                       н
0041
                                                ; fifo empty?
         34
                               INR
         C2 0244
                                       STFIFO ; no, store to fifo
0042
                               JNZ
0045
         28
                               DCX
                                       н
                                                ; leadin
 0046
                               ORA
         В6
0047
         3A 9000
                               LDA
                                        ACEDTA ; read ace
 004A
         FB
                               ΕI
         CS 0583
 004B
                               JNZ
                                       LINMDE ; leadin mode
004E
         E6 7F
                       FIFACE: ANI
                                        07Fh
0050
         11 0267
                               LXI
                                        D, FFCHK
                               PUSH
                                       D
LF
 0053
         D5
                                               ;pseudo call
0054
         FE OA
                               CPI
                                        LFEED
 0056
         CA 03B1
                               JΖ
0059
         CD 015C
                               CALL
                                        CALJMP
 005C
         E6 87
                               ANI
                                        087h
                                                ;leadin+jmp addr high
 005E
         F8
                               RM
                                                ; leadin required, return
005F
         67
                       LCLFUN: MOV
                                                ijmp addr high
                                        H. A
         E9
                               PCHL
                                                do function
0060
                       ;row interrupt continue
                        **********
 0061
         3E 01
                       VRWRAP: MVI
                                        A, 1
 0063
         32 5000
                               STA
                                        05000h
                                               wrap arround addr
 0066
         D3 40
                       NOWRAP:
                               DUT
                                        ROWPRT ; clr row flip/flop
                               POP
8800
         F1
0069
         FB
                               ΕI
006A
         C9
                               RET
                       :WRITE TO ACE
                       : ************
 006B
         3E OD
                       SNDCR: MVI
                                        A, CR
 006D
         57
                       WTACEA: MOV
                                        D, A
 006E
         3A 9005
                                        ACESTU ; check status
                       WTACED: LDA
0071
         FE 60
                               CPI
                                        060h
                                             · ;hold/tx register
                                        WTACED ; not ready
 0073
         DA 006E
                               JC
 0076
         CD 075E
                                        $DLY
                               CALL
                                                idelau
 0079
                       DUTACE: MOV
007A
         32 9000
                               STA
                                        ACEDTA ; write to ace
 007D
         C9
                               RET
                       PAGE
```

```
STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
CRTRO1
  007E
                           ROW START LOOKUP TABLE
                                                          (start addr=7Eh)
  007E
           3EB0
                           ROW47D: dw
                                             O3EBOh
  0080
           3000
                           ROW48D: dw
                                             03000h
  0082
           3050
                           ROW1:
                                             03050h
                                    dω
  0084
           30A0
                           ROW2:
                                             030A0h
                                    dω
  0086
           30F0
                           ROW3:
                                    dω
                                             030F0h
  0088
           3140
                           ROW4:
                                    đω
                                             03140h
  008A
           3190
                           ROW5:
                                    ďω
                                             03190h
  0080
           31E0
                           ROW6:
                                             031E0h
           3230
                           ROW7:
                                             03230h
  008E
                                    ďω
  0090
           3280
                           ROW8:
                                             03280h
                                    ďω
  0092
           32D0
                           ROW9:
                                    ďω
                                             032D0h
  0094
           3320
                           ROW10:
                                             03320h
                                    dω
  0096
                           R0W11.
                                             03370h
           3370
                                    dш
  0098
           33C0
                           ROW12:
                                    dω
                                             033C0h
  0094
           3410
                           ROW13:
                                    ďω
                                             03410h
  009C
           3460
                           ROW14:
                                    ďω
                                             03460h
  009E
           34B0
                           ROW15:
                                    dω
                                             034B0h
  00A0
           3500
                           ROW16:
                                    dω
                                             03500h
  00A2
           3550
                           ROW17:
                                             03550h
                                    dω
  00A4
           35A0
                           ROW18:
                                    ďω
                                             035A0h
                                             035F0h
  00A6
           35F0
                           ROW19:
                                    ďΨ
  00A8
           3640
                           ROW20:
                                             03640h
                                    dω
  OOAA
           3690
                          R0W21:
                                             03690h
                                    dω
  COAC
                           ROW22:
                                             036E0h
           36E0
                                    dω
  COAE
           3730
                           R0W23:
                                    ďω
                                             03730h
  OOBO
           3780
                           ROW24:
                                             03780h
                                    dω
  00B2
           37D0
                           R0W25:
                                    dω
                                             037D0h
  00B4
           3820
                           R0W26:
                                    ďω
                                             03820h
  00B6
           3870
                           ROW27:
                                    dω
                                             03870h
  оовв
           3800
                           ROW28:
                                             038COh
                           ROW29:
                                             03910h
  COBA
           3910
                                    ďω
           3960
  OOBC
                           ROW30:
                                             03960h
                                    dω
  OOBE
           39B0
                           ROW31:
                                             039B0h
                                    dω
                           ROW32:
                                             03A00h
  ooco
           3A00
                                    dω
           3A50
                           ROW33:
                                             03A50h
  0002
                                    ďω
                           ROW34
                                             OBAACH
  00C4
           3AA0
                                    dω
                                             O3AFOh
                           ROW35:
  0006
           3AF0
                                    dω
  0008
           3B40
                           ROW36:
                                    đω
                                             03B40h
  OOCA
           3B90
                           ROW37:
                                             03B90h
           ЗВЕО
                           ROW38:
                                             O3BEOh
  OOCC
                                    dω
                           ROW39:
  OOCE
           3030
                                    ďΨ
                                             03C30h
  OODO
           3080
                           ROW40:
                                    dω
                                             03C80h
  00D2
           3CD0
                           ROW41:
                                    dω
                                             O3CDOh
  00D4
           3D20
                           ROW42:
                                             03D20h
                                    dω
                                             03D70h
           3D70
                           ROW43:
  00D6
                                    ďΨ
  OODS
           3DC0
                           ROW44
                                             OBDCOR
                                    dω
                           ROWAS:
  OODA
           3E10
                                    đω
                                             .03E10h
  OODC
           3E60
                           ROWAS:
                                    dω
                                             03E60h
  OODE
           3EBO
                           ROW47:
                                    ďω
                                             O3EBOh
  00E0
           3F00
                           ROW48:
                                    dω
                                             03F00h
                           PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
CRT801
  00E2
                          INITIALIZE
                           ; *********
  00E2
           3E 20
                           INIT:
                                   MUI
                                             A, SPC
                                                     ; space
  00E4
           16 E9
                                   MVI
                                             D, low LEADIN; byte count
  00E6
           CD 04C7
                                   CALL
                                             DRLLP
                                                     store spaces
  00E9
           AF
                                    XRA
           32 3FA2
                                             LINWCT ; zero leadin word count
  00EA
                                    STA
  OOED
           16 17
                                   IVM
                                             D. 256-low LEADIN; byte count
           CD 04C7
                                             DRLLP
  OOEF
                                   CALL
                                                     ;store zeros
           31 3FE7
                                             SP, STK+2
  00F2
                                   IXI
  00F5
           21 5050
                                             H, 05050h
                                   LXI
  00F8
           E5
                                   PUSH
                                             н
                                                      ;set up fifo rd/wrt ptrs
  00F9
           CD 04AE
                                   CALL
                                             CURULK
                                                    ; enable cursor, unlock kbd
  OOFC
           32 3FEA
                                    STA
                                             FFWCT
                                                      ; zero fifo word count(FFh)
  OOFF
           23
                                    INX
                                             н
                                                      RTECTL
                                             M, O1Ch
  0100
           36 1C
                                    MVI
                                                     cursor blink cntl
  0102
           2E FC
                                    MVI
                                             L, low LROW; last row
  0104
           36 BO
                                    MVI
                                             M. low RR24
  0106
                                             Lilow FROW; first row
           2E FE
                                    MVI
  0108
           36 82
                                    MVI
                                             M. low RR1
                                             KBDPRT
  010A
           DB 80
                                    TN
                                                     clear keyboard intr
  010C
           CD 04CE
                                    CALL
                                             CLRSCN
                                                      ; clear screen
  010F
           CD O7BF
                                    CALL
                                             ACESW
                                                      ; init ace, read setsw
  0112
           3E 3F
                           PATTN:
                                    MVI
                                             A, O3Fh
  0114
           21 3780
                                    LXI
                                             H.FCHR2 :1st byte of page 2
  0117
           75
                           PTNLP:
                                    MOV
                                             M, L
                                                      ; write pattern
  0118
           23
                                    INX
                                    CMP
                                             н
  0119
           BC
```

```
011A
           C2 0117
                                   JNZ
                                            PTNLP
  011D
           D3 01
                                   OUT
                                            BELPRT ; ring bell for ready
                          ; CALCULATE SCREEN ADDR AFTER VERTICAL INTERRUPT
  011F
           2E EB
                          VCAL:
                                   MVI
                                            L, low CURTMR
  0121
           7E
                                   MOV
                                            A. M
                                   CMA
  0122
           2F
                                                     cursor timer
  0123
           34
                                   INR
  0124
           23
                                   INX
                                            н
                                                     cursor enable
  0125
           A6
                                   ANA
                                            М
  0126
                                   INX
                                                     ;rate cntl
                                   ANA
                                            М
                                                     ; blink rate mask
  0127
           A6
  0128
           C4
              0174
                                   CNZ
                                            CURLOC
                                                     ; cursor on
  0128
           3E
              20
                                   MVI
                                            A, 020h
                                                     ;8350 offset
  012D
                                   ADD
                                            н
                                                     ; offset addr high
           84
                                                     ;=5Fh if cursor off
  012E
           67
                                   MOU
                                            H, A
                                   PUSH
  012F
           E5
                                            н
                                                     ; save cursor
              3FFE
                                            FROW
  0130
           2A
                                   THID
  0133
           28
                                   DCX
                                            н
                                                     ; fetch row start
  0134
           7E
                                   MOV
                                            A, M
  0135
           63
              20
                                   ADI
                                            020h
                                                     ; offset addr high
                                   MOV
                                            D. A
  0137
           57
                                   DCX
  0138
           2B
                                            н
                          PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                            PAGE
                                                     6
CRTRO1
  0139
  0139
           5E
                                   MOV
                                            E, M
                                                     ide=top of page
                                   MOV
                                                     ; calc row wrap constant
  013A
           7D
                                            A, L
                                   RRC
                                                     divide by 2
  013B
           OF
  0130
           C6
              8F
                                   ADI
                                            08Fh
                                                     ; add offset
  013E
                                   POP
                                                     cursor location
           F1
                                            н
                                   DΙ
  013F
           F3
              3FF8
                                            CUR
  0140
           22
                                   SHLD
                                                     ; update cursor
  0143
           EB
                                   XCHG
  0144
           22
              3FF6
                                   SHLD
                                            TOP
                                                     ;update top of page
  0147
           21
              3FF5
                                   LXI
                                            H, NRW
                                                     ;row wrap constant
  014A
                                   MOV
                                            M, A
  014B
           28
                                   DCX
                                            н
                                                     ; VCALEN
  014C
           36 00
                                   MVI
                                            M, O
                                                     ; disable VCAL routine
  014E
           FΒ
                          WAIT:
                                   ΕI
  014F
                                   HLT
           76
  0150
                                            A, M
                                                     ; VCALEN
           7E
                                   MOV
                                   ORA
  0151
           B7
                                                     ; check from vert intr
  0152
           CA 014E
                                   .17
                                            WAIT
                                                     ; no
                                   JMP
                                            VCAL
  0155
           C3 011F
                                                     ; do screen calculations
                          ; CALCULATE JMP
                                           ADDR
  0158
           2E E9
                          CJMP:
                                   MVI
                                            L. low LEADIN
           E6 7F
  015A
                                   ANI
                                            07Fh
                                                     ; mask 1st bit
  015C
           FE 20
                          CALJMP:
                                   CPI
                                            SPC
                                            FUNC
                                                     , 0-1Fh, func
  015E
           DA 0168
                                   JC
                                   CPI
                                            07Eh
  0161
           FF 7F
  0163
           DA 0372
                                   JC
                                            CHAR
                                                     ;20-7Dh, char input
                                                     ;7E/7Fh to 20/21h
  0166
           D6 5F
                                   SUI
                                            05Eh
  0168
           28
                          FUNC:
                                   DCX
                                            н
                                                     ; insert mode
  0169
           74
                                   MOV
                                            M, H
                                                     ;h<>0.defeat insert mode
  016A
           07
                           JMPADD:
                                   RLC
                                                     ; *2, msb=0
  016B
           5F
                                   MOV
                                            E, A
                                                     ;d=02h (jmp tb1)
                                   LDAX
                                            D
                                                     ; fetch jmp addr low
  016C
           1A
           6F
  016D
                                   MOV
                                            L, A
  016E
           13
                                   INX
                                            D
  016F
                                   LDAX
                                            D
                                                     ; fetch imp addr high
           1A
  0170
           C9
                                   RET
                          CALCULATE CUR LOC AND CUR TO END DIFF
                          DFCLOC: MVI
                                            A, 80
  0171
           3E 50
  0173
           90
                                   SUB
                                            В
                                                     cursor to end difference
                          CALCULATE CURSOR LOCATION
  0174
              3FFA
                          CURLOC: LHLD
                                            CROW
  0177
           28
                                   DCX
                                            н
  0178
           56
                                   MOV
                                            D. M
  0179
                                   DCX
                                            н
           28
  017A
           5F
                                   MOV
                                            F. M
  017B
                                   MOV
           68
                                            L, B
  017C
           19
                                   DAD
                                            D
                                                     ; hl=cursor address
  017D
           C9
                                   RET
                          PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                            PAGE
                                                     7
CRTSO1
  017F
                          FROW WRAP AROUND LOOKUP TABLE
                                                              (start addr=17Eh)
                           : ***********
  017E
           00E0
                          RR47D:
                                   ďω
                                            00E0h
  0180
           0082
                          RR48D:
                                   dω
                                            0085P
                          RR1:
                                            0084h
  0182
           0084
```

0184

0186

0086

0088

RR2:

RR3:

dω

0086h

0088h

```
0188
            008A
                            RR4:
                                      ďω
                                               008Ah
  018A
            0080
                            RR5:
                                      dω
                                               008Ch
            008E
  0180
                            RRA.
                                      dω
                                               COREN
  018E
            0090
                            RR7:
                                               0090h
                                      dω
            0092
                            RR8:
                                               0092h
  0190
                                      dω
  0192
            0094
                            RR9:
                                      dω
                                               0094h
  0194
            0096
                            RR10:
                                      dω
                                               0096h
  0196
            0098
                            RR11:
                                      d₩
                                               0098h
  0198
            009A
                            RR12:
                                               009Ah
                                      ďω
  019A
            009C
                                               009Ch
                            RR13:
                                      ďω
  0190
            009E
                            RR14:
                                      dω
                                               009Eh
  019E
            00A0
                            RR15:
                                      dω
                                               00A0h
  01A0
            00A2
                            RR16:
                                               00A2h
                                      dω
            00A4
  01A2
                            RR17
                                      dω
                                               00A4h
  01A4
            00A6
                                               00A6h
                            RR18:
                                      dω
  01A6
            BACO
                            RR19:
                                      dω
                                               00A8h
  01A8
            OOAA
                            RR20:
                                      dω
                                               OOAAh
  01AA
            OOAC
                            RR21:
                                      dω
                                               OOACh
  01AC
            OOAE
                            RR22
                                               OOAEh
                                      dω
  01AE
            00B0
                                               OOBOh
                            RR23:
                                      dω
  0180
            00B2
                            RR24:
                                      dω
                                               00B2h
  0182
            OOR4
                            RR25
                                      ďω
                                               OOB4h
  0184
            00B6
                            RR26:
                                               00B6h
                                      ďш
           00B8
                                               00BBh
  01B6
                            RR27:
                                      dω
  0188
            OOBA
                            RR28:
                                      ďω
                                               OOBAh
  01BA
            OOBC
                            RR29:
                                      dω
                                               OOBCh
  O1BC
            OOBE
                            RR30
                                      dω
                                               OOBEh
  01BE
            0000
                            RR31:
                                               OOCOh
                                      ďω
  01C0
            0002
                            RR32:
                                      dω
                                               00C2h
  0102
            00C4
                            RR33:
                                      dω
                                               00C4h
           0006
  01C4
                            RR34:
                                      ďω
                                               00C6h
  0106
            00CB
                            RR35:
                                               OOCBh
                                      dω
                                               OOCAh
  0108
            OOCA
                            RR36:
                                      ս հ
                                               OOCCh
  01CA
            oocc
                            RR37
                                      dω
  O1CC
            OOCE
                            RR38:
                                      ďω
                                               OOCEh
  01CE
            OODO
                            RR39:
                                      ďω
                                               OODOh
  01D0
            0002
                            RR40:
                                      ďω
                                               00D2h
  0102
            00D4
                            RR41
                                      ďω
                                               00D4h
  01D4
            00D6
                            RR42:
                                               00D6h
                                      đω
  01D6
            OODB
                            RR43:
                                      dω
                                               00DBh
  01D8
            OODA
                            RR44:
                                               OODAh
                                      dω
  01DA
            OODC
                            RR45:
                                      đω
                                               OODCh
  01DC
            OODE
                            RR46:
                                      dω
                                               OODEh
  01DE
            COFO
                            RR47
                                               OOEOh
                                      ďω
  01E0
            0082
                            RR48
                                      dω
                                               0082h
  01E2
            0084
                            RR1D:
                                      ďω
                                               0084h
 STARPLEX MACRO-ASSEMBLER V2. 0
                                               PAGE
                                                        8
CRT801
                            JUMP ADDRESS CONSTANTS
                            ; ****
                                     *****
                            ; A15
                                       - O=no leadin required
                                      :- parameter count
:- O=local function
equ O1000h ;on
                            ; A14/A12: -
                            ; A11
  1000
                            W1
                                                        ; one para adder
  2000
                            W2
                                      equ
                                               02000h
                                                         ;two para adder
  8000
                            LIN
                                      equ
                                               08000h
                                                        ; leadin adder
  0800
                            NLC
                                               00800h
                                                         ; not local adder
                                      equ
  0A5F
                            F1
                                               RTN+NLC
                                      equ
                                               CARRTN
  0389
                            F2
                                      equ
  03B1
                            FЗ
                                               LFEED
                                      equ
                            F4
  OC34
                                      equ
                                               BELL+NLC
                            F5
  060A
                                               TAB
                                      equ
  0437
                            F6
                                      equ
                                               FS
                            F7
  041F
                                      equ
                                               BS
  844E
                            F8
                                               UPCUR+LIN
                                      equ
  8460
                            F9
                                               DWNCUR+LIN
                                      equ
  84D8
                            F10
                                      equ
                                               HOMCUR+LIN
  85F3
                            F11
                                               NPAGE+LIN
                                      equ
  8472
                                               ROLUP+LIN
                            F12
                                      equ
  848C
                            F13
                                               ROLDWN+LIN
                                      equ
  84AE
                            F14
                                      equ
                                               CURULK+LIN
                            F15
                                               RDCUR+LIN+NLC
  8DD1
                                      equ
                            F16
  ADA2
                                      equ
                                               ADDCUR+LIN+NLC+W2
  84F1
                            F17
                                      equ
                                               FGNDF+LIN
  84F7
                            F18
                                               BGNDF+LIN
                                      equ
  836B
                                                INSCHAR+LIN
                            F19
                                      equ
  8358
                            F20
                                               STOFCH+LIN
                                      equ
  8505
                            F21
                                               INSLNE+LIN
                                      equ
  8512
                            F22
                                               STOFLNE+LIN
                                      equ
  AD26
                                                ISLRG+LIN+NLC+W2
                            F23
                                      equ
  9E8A
                            F24
                                      equ
                                               GRAPH+LIN+NLC+W1
```

```
0419
                           F25
                                    equ
                                             DEL
  83DB
                           F26
                                             DCROW+LIN
                                    equ
                                             DRTLN+LIN
  B4C0
                           F27
                                    equ
  84BA
                           F28
                                             DRTPG+LIN
                                    equ
                           F29
                                             CFB+LIN
  8642
                                    equ
                                             CLRSCN+LIN
  R4CE
                           F30
                                    equ
                           F31
                                             KBLK+LIN+NLC
  8CB6
                                    equ
  801B
                           F32
                                    equ
                                             DICUR+LIN
  871D
                           F33
                                    eqυ
                                             SNDLNE+LIN
  87BF
                           F34
                                             ACESW+LIN
                                    equ
  OAC5
                           F35
                                    equ
                                             LINSET+NLC
                                             DEGRPH+LIN
  86BC
                           F36
                                    equ
                           PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
CRT801
  01E4
                           ; PUT A WORD TO ACE
  01E4
                           KBDACE: MOV
                                             D, A
           3A 9005
  01E5
                                    LDA
                                             ACESTU
  01E8
           E6 20
                                    ANI
                                             020h
  01EA
           CA 01E5
                                             KBDACE+1; not ready
                                    JZ
  OIFD
           C3 0079
                                    JMP
                                             DUTACE
                           ; ACE BAUD RATE CONSTANTS
  01F0
           06AB
                           B110:
                                    dω
                                             1707
  01F2
           0139
                           B600:
                                             313
                                    ďω
  01F4
           009C
                           B1200:
                                                     ; 0. 3%
                                    dω
                                             156
                                                     ; 0. 3%
  01F6
           004E
                           B2400:
                                             78
                                    dω
  01F8
           0027
                           B4800:
                                             39
                                                      ; 0. 3%
                                                               4
                                    dω
  01FA
           0014
                           B9600:
                                             20
                                    dы
                                                      ; 2. 3%
                                                               5
  01FC
           OOOA
                           B19200: du
                                             10
                                                      ; 2, 3%
                                                               6
  01FF
           0005
                           B38400: dw
                                             5
                                                     ; 2. 3%
                                                               7
                                                      (start addr=200h)
                           FUNCTION JUMP TABLE
  0200
           0A5F
                           TBLJMP: dw
                                             F1
                                                     ;null/toggle local
  0505
           8472
                                            F12
                                                      A: roll up
                                    dω
  0204
           9E8A
                           CB:
                                            F24
                                                      ; B: graphics mode
                                    dω
           84AF
  0206
                                             F14
                                                      ; C: on cursor/unlock kbd
                                    ďω
                                             F20
                                                      ;D: strip off character
  0208
           8358
                                    dω
  020A
           8DD1
                           CE:
                                    dω
                                            F15
                                                      ; E: read cursor
                                                      ;F:disable cursor
  0200
           801B
                                    dω
                                             F32
  020E
           0034
                           CG:
                                    ďω
                                             F4
                                                      ; G: bell/scale
  0210
           041F
                                             F7
                                                      ;H:cursor left
                                    dω
  0212
           060A
                                    dω
                                             F5
                                                     ; I: tab
  0214
                                                      J: line feed
           03B1
                                    dω
                                             F3
                                             F9
  0216
           8460
                                    ďω
                                                      K: cursor down
  0218
           844E
                                             F8
                                    dω
                                                      :L: cursor up
  021A
           0389
                                             F2
                                    du
                                                      ;M:carriage return
  0210
           85F3
                                            F11
                                    dω
                                                      ; N: next page
  021F
           84C0
                                    ďΨ
                                            F27
                                                      ;O: delete rest of line
  0220
           0437
                                    ďω
                                            F6
                                                      ;P:cursor right
  0222
           ADA2
                           CQ:
                                    đω
                                            F16
                                                      ; Q: address cursor/menu
  0224
           84D8
                                    ďω
                                             F10
                                                     ;R:home cursor
  0226
           8512
                                    dω
                                             F22
                                                     ;S:strip off a line
  0228
           871D
                                    ďω
                                             F33
                                                     ;T: transmit a line
                                                     ;U:lock keyboard
;V:roll down
           8CB6
                           CiJ:
  022A
                                    ďω
                                             F31
  0220
           848C
                                             F13
                                    dω
                                             F28
  022E
           84BA
                                    ďш
                                                      ; W: delete rest of page
  0230
           8642
                                    ďω
                                             F29
                                                      ; X: clear fore/background
  0232
           84F7
                                    đω
                                             F18
                                                      ; Y: background follows
  0234
           8505
                                    ďω
                                             F21
                                                      ¿Z: insert line
  0236
           86BC
                                    ďω
                                             F36
                                                      ;1B:esc/defeat graphics
  0238
           84CE
                                    dω
                                             F30
                                                      ; 1C: home and clear screen
  023A
           AD26
                           C1D:
                                    ďω
                                             F23
                                                      ; 1D: insert/strip lne/rng
  0230
           836B
                                    dω
                                             F19
                                                      ; 1E: insert character
  023E
           84F1
                                             F17
                                                      ; 1F: foreground follows
                                    dш
                                                      ; 7E: leadin/ace, u/l-case
  0240
           OAC5
                           C7E
                                             F35
                                    đω
  0242
                                             F25
                                                      :7F:delete
           0419
                                    dω
 STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
                                                      10
CRT801
                           STORE A WORD TO ACE FIFO
  0244
                           STFIFO: MVI
           3E 50
                                             A, 80
  0246
           ΒE
                                    CMP
                                                      ; exceeding 80 words?
  0247
           3A 9000
                                    LDA
                                             ACEDTA
                                                     read ace
  024A
           DA 032C
                                    JC
                                             OVRNG
                                                      ; more than 80 words
  024D
                                             L, low FFWRT
                                    MVI
           2E E6
                                             D, H
  024F
           54
                                    MOV
                                                      ;set up write pointer high
  0250
           5E
                                    MUV
                                             E, M
                                                      ; set up write pointer low
  0251
           12
                                    STAX
                                             D
                                                      ; store to fifo
  0252
           7B
                                    MOV
                                             A, E
  0253
           30
                                    INR
                                                      ;advance pointer
  0254
           FE AO
                                    CPI
                                             low FFEND+1; exceeding 80 words?
  0256
           DA 025A
                                    JC
                                             WFFRNG
                                                    ;less than 80 words
  0259
                                    RAR
                                                      ; fifo start again
```

```
025A
           77
                           WFFRNG: MOV
                                             M, A
                                                      ; advance write pointer
  025B
           FB
                                    ΕI
           D1
                           CMRTN:
  0250
                                    POP
                                             D
                                    POP
                                             PSW
  025D
           F1
  025E
           Εi
                                    POP
                           ; (FUNCTION) unused keys
  025F
           C9
                                    RET
                           ; KEY BOARD RETURN, addr high=2h
  0260
           AF
                           KLCRTN: XRA
                                             Α
                                                     ; enable keyboard
  0261
           32 '3FEE
                                             KBDLCK
                                    STA
  0264
           C3 025C
                                    . IMP
                                             CMRTN
                           ; CHECK FIFO AND RETURN, addr high=2h
  0267
           21 3FEA
                                    LXI
                                             H, FFWCT ; fifo word count
                           FFCHK:
  026A
                                    DCR
                                                      ififo empty?
  026B
           FA 025C
                                    JM
                                             CMRTN
                                                      ; empty
                           READ A WORD FROM ACE FIFO
                           RDFIFO: MVI
 02AE
           2E E5
                                             L, low FFRD
 0270
           54
                                    MOV
                                             D, H
                                                      ;set up read pointer high
  0271
           5E
                                    MOU
                                             E, M
                                                      ; set up read pointer low
  0272
           7B
                                    MOV
                                             A, E
  0273
           30
                                    INR
                                             A ;advance read pointer low FFEND+1;exceeding 80 words?
  0274
           FE AO
                                    CPI
  0276
           DA 027A
                                    JC
                                             RFFRNG ; less than 80 words
  0279
           1F
                                    RAR
                                                      ; fifo start again
                                    MOV
                                                      ; store read pointer
  027A
           77
                           RFFRNG:
  027B
           2E E9
                                    MVI
                                             L, low LEADIN
           7E
                                    MOV
  0270
                                             A. M
                                    ORA
           87
                                                      ;leadin mode=0?
  027F
                                             Α
                                                      ;read fifo word
  027F
           1A
                                    LDAX
                                             D
           CA 004E
                                             FIFACE
                                                      ; not leadin, normal entry
  0280
                                    JZ
                           PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
                                                      11
CRT801
 0283
                           LEADIN MODE
 0283
           E6.7F
                                             07Fh
                           LINMDE: ANI
                                                      ;mask input
  0285
           11 0267
                                    LXI
                                             D, FFCHK
 0288
           D5
                                    PUSH
                                             D
                                                      ;pseudo call
  0289
           2E A2
                                    MVI
                                             L, low
                                                    LINWCT
  028B
           5E
                                    MOV
                                             E, M
                                                      ; leadin word count
  0280
           1 D
                                    DCR
                                             E
                                                      :word count=0?
  028D
           F2 02B3
                                    JP
                                             LINPRA
                                                      ; parameter entries
                                    CPI
                                                      control codes?
  0290
           FF 20
                                             SPC
           D2 02C2
  0292
                                    JNC
                                             TLELIN
                                                      ; not cntl code, error
  0295
           CD 016A
                                    CALL
                                             JMPADD
                                                      ; fetch jmp address
  0298
           B7
                                    ORA
  0299
           F2 02C2
                                    JP
                                             ILELIN
                                                      ; code requires no leadin
  0290
                                    ANI
                                                      ; word count/jmp addr high
           E6 77
                                             077h
  029E
                                    MOV
           67
                                             H, A
                                                      ; save
                                                      ; mask word count
  029F
           E6 70
                                    ANI
                                             070h
  02A1
           CA 02BE
                                             LINEXE ; do function
                                    JΖ
                                    RRC
 02A4
           ٥E
                           LINPEN:
                                                      ;right justify word count
 02A5
           OF
                                    RRC
           OF
  02A6
                                    RRC
 02A7
           0F
                                    RRC
  02A8
           32
              3FA2
                                    STA
                                             LINWCT
                                                      ; store to word count reg
  02AB
           3E
              07
                                    MVI
                                             A, 07h
  02AD
           Α4
                                    ANA
                                                      ; get imp addr high
  02AE
           67
                                    MOV
                                             H, A
  02AF
           22 3FA0
                                    SHLD
                                             LINF
                                                      ;save function jmp addr
  0282
           C9
                                    RET
 0283
           73
                           LINPRA: MOV
                                             M, E
                                                      ; leadin word count-1
  02B4
           16 00
                                    MVI
                                             D, O
                                                      ; d=O, e=word count-1
  0286
           23
                                    INX
                                             н
                                                      ; LINP
           19
                                             D
  02B7
                                    DAD
                                                      ;hl=para pointer
  0288
           77
                                    MOV
                                             M, A
                                                      ; store word
                                                      ;word count<>0, next word ;load leadin jmp address
  0289
           CO
                                    RN7
  02BA
           2A 3FA0
                                    LHLD
                                             LINE
  02BD
           AF
                                    XRA
  02BE
           32 3FE9
                           LINEXE:
                                    STA
                                             LEADIN
                                                      ;defeat leadin
  0201
           E9
                                    PCHL
                                                      ; do function
                           ILELIN: OUT
                                             BELPRT
  0202
           D3 01
                                                      ; illegal code after leadin .
  0204
           AF
                                    XRA
                                                      ;a=0, reset leadin
```

LINSET: STA

LEADIN ;a<>0, set leadin

PAGE

```
STARPLEX MACRO-ASSEMBLER V2. 0
                                           PAGE
                                                    12
CRT801
  0209
                          ; keyboard interrupt continue
 0209
                          KBDĪNT: XRA
                                           CURTMR
  02CA
          32 3FEB
                                   STA
                                                    reset cursor blink timer
  02CD
          B6
                                   ORA
                                                    :keyboard locked?
  02CE
          DB 80
                                   IN
                                            KBDPRT
                                                    read keyboard
  02D0
                                   ΕI
          FB
  02D1
                                   PUSH
          D5
  0202
          C2 0327
                                   JNZ
                                            KNACTV ; keyboard not active
  0205
          B7
                                   ORA
          CA 0333
                                            TGLCL
                                                    ;toggle local
  0206
                                   .17
                                                    idefeat graphics
                                   MOV
  02D9
          77
                                            M, A
                                                    ilock keyboard
                                            D. KLCRTN
  02DA
           11 0260
                                   LXI
  02DD
          D5
                                   PUSH
                                            D
                                                    ; generate pseudo call
                                   INX
                                                    GECNTL
  02DE
          23
  02DF
          B6
                                   ORA
  02E0
          23
                                   INX
                                                    ULCASE
                                   CPI
                                            061h
  02E1
          FE 61
          DA OZEC
FE 7B
                                   JC
                                            NLCSE
  02E3
                                                    inot lower case
                                   CPI
                                            O7Bh
  02E6
          D2 02EC
                                   JNC
                                            NLCSE
  02E8
                                                    inot lower case
  02EB
          96
                                   SUB
                                            м
                                                    ; u/l case cntl, m=20h/0
  02EC
          23
                          NLCSE:
                                   INX
  02ED
          5E
                                   MOV
                                            E, M
  02EE
          1 C
                                   INR
                                                     :local mode?
  02EF
          C2 01E4
                                            KBDACE
                                                    ; write to ace
  02F2
          FE AO
                          LCL:
                                   CPI
                                            OAOh
                                                    ;parameter entru?
  02F4
          D2 068D
                                   JNC
                                           LCPARA
                                                    iyes
                                            CUMP
          CD 0158
                                   CALL
  02F7
                                                    ∤get jmp addr
  02FA
          E6 OF
                                   ANI
                                            OFh
          FE 08
  02FC
                                   CPI
                                            08h
                                                    ;local?
  02FE
          DA 005F
                                   JC
                                            LCLFUN
                                                   ; do local function
  0301
                                   MOV
                                                    read lookup thl ptr
          7B
                                            A, E
          FE 05
                                   CPI
                                            low CB+1; cntl B?
  0302
                                            ENGRPH ; enable graphics mode
  0304
          CA 0687
                                   JΖ
  0307
                                   CPI
                                            low CE+1; cnt1 E?
          FE OB
                                            LRDCUR : display cursor location
  0309
          CA 0773
                                   JΖ
                                   CPI
          FE OF
                                            low CG+1; cntl G?
  0300
          CA 0784
                                            SCALE
  030E
                                   JZ
                                                    ; put scale
                                            low CQ+1; cnt1 Q?
                                   CPI
  0311
          FE 23
  0313
          CA 06D5
                                   JZ
                                            PGM
                                                    ; put graphics menu
                                            1οω C7E+1
  0316
          FE 41
                                   CPI
  0318
          CA O7CD
                                   JΖ
                                            ATGUL
                                                    ; init ace, toggle u/l case
  031B
          FE 3B
                                   CPI
                                            1ow C1D+1
                                   JΖ
                                            ROM2
                                                    ; do rom2 functions
  031D
          CA 034F
  0320
          FE 2B
                                   CPI
                                            low CU+1; cntl U?
                          PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                            PAGE
                                                     13
CRTR01
  0322
                                   RNZ
  0322
          CO
                                                    unused keys
  0323
          D1
                                   POP
                                                    ;pseudo rtn+lock kbd
          C3 0261
                                   JMP
                                            KLCRTN+1
  0324
                          KNACTV: XRI
                                            KULCDE :lock/unlock kbd?
  0327
          EE 03
  0329
          CA 025A
                                   JZ
                                            CMRTN-2 ; unlock keyboard
  0320
          3E 50
                          OVRNG:
                                   MVI
                                            A, 80
                                                    ifor FFWCT
  032E
          D3 01
                                   OUT
                                            BELPRT
  0330
          C3 025A
                                   JMP
                                            CMRTN-2 ; lock kbd
  0333
          23
                          TGLCL:
                                   INX
                                                    GECNTL
          77
  0334
                                   MOV
                                            M. A
                                                    idisable graphics mode
                                            LEADIN
          32 3FE9
  0335
                                   STA
                                                    ;reset leadin
                                            L. low LOCLM
  0338
          2E F1
                                   MUI
  033A
          7E
                                   MOV
                                            A, M
  033B
          2F
                                   CMA
                                                    ; toggle local
  0330
          77
                                   MOV
  033D
          CD 07EB
                                   CALL
                                            EDACE
                                                    ;en/disable ace
  0340
          C2 0345
                                   JNZ
                                            ONLINE
  0343
          3E 1E
                                   MVI
                                            A, O3h XOR O1Dh
  0345
          EE 1D
                          ONLINE: XRI
                                            O1Dh
```

5

```
0347
                                                       out 1clprt
           00
                                     nop
  0348
           00
                                     nop
STA
           32 3FED
                                              RTECTL
                                                       ; select blink rate
  0349
                                              CMRTN
  034C
           C3 025C
                                     . IMP
                           JMP TO ROM2
  034F
           3A 0800
                           ROM2:
                                     LDA
                                              0800h
                                                       ; check presence of rom2
  0352
           FE 55
                                     CPI
                                              055h
                                                       ; =55h?
  0354
           CO
                                     RNZ
                                                       ;not exist
  0355
           C3 0801
                                     JMP
                                              0801h
                                                       iok, do jmp
                           ;{FUNCTION} stripe off a character
STOFCH: CALL DFCLOC ;get cur 1
  0358
           CD 0171
                                                      get cur loc and diff
  035B
                                     DCR
           ЗD
                                              BELL
  035C
           CA 0434
                                     .17
                                                       ; last column, error
  035F
           23
                           STOFLP:
                                     INX
                                              н
  0360
           56
                                     MOV
                                              D. M
  0361
           2B
                                     DCX
  0362
           72
                                     MOV
                                              M, D
                                                       ido copy
  0363
           23
                                     INX
  0364
           ЗD
                                     DCR
                                              STOFLE
  0365
           C2 035F
                                     JNZ
                                              PSPC
  0368
           C3 03A4
                                     JMF
                                                       ; put a space
                            ; (FUNCTION) insert character
  036B
                            INSCHAR: XRA
           32 3FE8
                                              ICMD
  0360
                                    STA
                                                        ; enable insert mode
  036F
           C3 038D
                                     JMP
                                              INSCHR
                           PAGE
                                              PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
CRTR01
  0372
                           CHARACTER INPUT
  0372
                                    POP
                                              D
           D1
                           CHAR:
                                                       ;pseudo return
                                     MVI
  0373
           2E 20
                                              L, low
  0375
           AE
                                     XRA
                                              M
                                                       ; add attribute
           AD
                                     XRA
                                              L
  0376
                                                       remove space code
  0377
                                     LHLD
           2A
              3FFA
                                              CROW
                                                       ; calculate cursor loc
  037A
           28
                                     DCX
                                              н
  037B
           56
                                     MUV
                                              D. M
  037C
           28
                                     DCX
                                              E, M
  037D
           5E
                                     MOV
                                              L, B
  037E
           68
                                     MOV
                                                       ; row start+cursor
  037F
           19
                                     DAD
                                              D
                                                       ; hl=cursor address
                                                       write to screen
  0380
           77
                                     MOV
                                              M, A
                                     MVI
  0381
           3E
                                              A, 79
              4F
  0383
                                     XRA
                                              В
                                                       ;last column?
           A8
                                              LSTCHR
                                     JZ
  0384
           CA
              0300
                                                       ; last, do scroll
  0387
                           MIDCHR:
                                     INR
                                                        :else advance cursor
           04
                                              R
                                              ICMD
  0388
           3A
              3FF8
                                     LDA
                                                       ; insert mode?
  038B
           R7
                                     DRA
  0380
           CO
                                     RNZ
                                                       ; not insert mode
  0380
           ЗΕ
                            INSCHR:
                                    MVI
                                              A, 79
                                     SUB
  038F
           90
                                                       ; byte counter
                                              ILCHAR
  0390
           CA O3AB
                                     JΖ
                                                       ; cursor at last column
  0393
           2A
              3FFA
                                     LHLD
                                              CROW
  0396
           5E
                                     MOV
                                              E, M
           23
                                     INX
  0397
                                              н
  0398
           56
                                     MOV
                                              D. M
                                                       ;d=row end+1
  0399
           1 B
                                     DCX
                                              D
                                                        row end
  039A
           EB
                                     XCHG
  039B
           2B
                            INSLP:
                                     DCX
  0390
           56
                                     MOV
                                              D, M
  039D
           23
                                     INX
  039E
           72
                                     MOV
                                              M, D
                                                       ido copu
  039F
           2B
                                     DCX
                                     DCR
  03A0
           ЗD
                                              INSLP
           C2 039B
                                     JN7
  03A1
  03A4
           ЗE
              80
                           PSPC:
                                     MUI
                                              A. 080h
  03A6
           A2
                                     ANA
                                                        ; get character attribute
  03A7
           F6
               20
                                     ORI
                                              SPC
                                                        ; add space
  03A9
                                     MOV
                                              M, A
  AAEO
           C9
                                     RET
  ОЗАВ
           30
                                     INR
                            ILCHAR:
                                                        ; make a<>0
           D3 01
                                     OUT
                                              BELPRT
  03AC
  03AE
           C3 03CE
                                     JME
                                              DICMD
                                                        ; defeat insert char mode
                            PAGE
```

```
STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
                                                      15
CRTB01
  03B1
                           (FUNCTION) line feed
  03B1
           3A 3FF2
                           LFEED:
                                    LDA
                                             AULF
                                                      ;auto line feed?
  03B4
           B7
                                    DRA
  03B5
           C2
              0301
                                    JNZ
                                             LFD
                                                      ; do line feed
  0388
           C9
                                    RET
                           ; {FUNCTION}
                                         carriage
                                                   return
  0389
           3A 3FF2
                           CARRTN: LDA
                                             AULF
                                                      ; auto line feed?
  OBBC
           B7
                                    ORA
  OBBD
           C2 04DE
                                    JNZ
                                             ZROCUR ido cr only
  0300
           47
                           LSTCHR: MOV
                                             B, A
                                                      ; set cursor to 1st col
  0301
           11 3FFC
                           LFD:
                                             D, LROW
                                    LXI
  0304
           2A 3FFA
                                    LHLD
                                             CROW
  0307
           24
                                    INR
                                             н
  0308
           1 A
                                    LDAX
                                             D
  0309
           BD
                                    CMP
                                             L
                                                      ;crow=lrow?
  03CA
           7E
                                    MOV
                                             A, M
                                                      ; next row
  ОЗСВ
           32
              3FFA
                                    STA
                                             CROW
                                                      ; crow+1
           32
  03CE
              3FE8
                           DICMD:
                                    STA
                                             ICMD
                                                      ;defeat insert char mode
  03D1
           co
                                    RNZ
                                                      ; not last row
  0302
           ΕB
                           LFSCR:
                                    XCHG
                                                      ; last row, do scroll
  03D3
           F3
                                    DI
  03D4
           77
                                    MOV
                                             M, A
                                                      ; lrow+1
  03D5
                                    MVI
                                             L, low FROW
           2E FE
  03D7
           5E
                                    MOV
                                             E, M
                                                      ide=row wrap arround tbl
  8000
           1A
                                    LDAX
                                             D
  03D9
           77
                                    MOV
                                             M, A
                                                      ; frow+1
  OGDA
           FB
                                    ΕI
                           ; {FUNCTION} clear cursor row
  OBDB
           2A 3FFA
                           DCROW:
                                   LHLD
                                             CROW
                           CLRROW: XCHG
  03DE
           EB
              0000
  O3DF
           21
                                    LXI
                                             H, O
  03E2
           39
                                    DAD
                                             SP
  03E3
           ΕB
                                    XCHG
  03E4
           F3
                                    DΙ
  03E5
           F9
                                    SPHL
  03E6
           E1
                                    POP
                                             н
                                                      ;lookup row start
                                    SPHL
  03E7
           F9
                                                      ;sp≖row start
  03E8
           FB
                                    ΕI
           2A 3F20
                                    LHLD
  03E9
                                             FBG
                                                      space + attribute
                           PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
                                                      16
CRTB01
  OBEC
  OBEC
           E5
                           PUSHSP:
                                   PUSH
                                             н
                                                      ido clear row
  03ED
           E5
                                    PUSH
                                             н
  03EE
                                    PUSH
           E5
                                             н
  OBEE
           E5
                                    PUSH
                                             Н
  03F0
           E5
                                    PUSH
                                             Н
  03F1
           E5
                                    PUSH
                                             н
  03F2
           E5
                                    PUSH
                                             н
  03F3
           E5
                                    PUSH
  03F4
           E5
                                    PUSH
                                             н
  03F5
           E5
                                    PUSH
                                             н
                                                      ; 10
  03F6
           E5
                                    PUSH
                                             н
  03F7
           E5
                                    PUSH
                                             н
  03F8
                                    PUSH
                                             н
           E5
                                             H
  03F9
           E5
                                    PUSH
  03FA
                                    PUSH
                                             Н
           E5
                                    PUSH
                                             н
  03FB
           E5
  03FC
           E5
                                    PUSH
                                             н
  03FD
           E5
                                    PUSH
                                             Н
  03FE
           Ē5
                                    PUSH
  03FF
           E5
                                    PUSH
                                             н
                                                      ; 20
  0400
           E5
                                    PUSH
                                             н
  0401
           E5
                                    PUSH
                                             н
 0402
           E5
                                    PUSH
                                             Н
           E5
  0403
                                    PUSH
  0404
                                             н
                                    PUSH
           E5
  0405
           E5
                                    PUSH
                                             н
  0406
                                    PUSH
                                             н
           E5
  0407
           E5
                                    PUSH
                                             Н
  0408
           E5
                                    PUSH
                                             Н
  0409
           E5
                                    PUSH
                                             н
                                                      ; 30
  040A
           E5
                                    PUSH
                                             н
  040B
           E5
                                    PUSH
  040C
           F3
                                    DΙ
```

```
040D
           E5
                                    PUSH
  040E
           E5
                                    PUSH
                                             н
  040F
           E5
                                    PUSH
                                             н
  0410
                                    PUSH
           E5
                                             н
  0411
           E5
                                    PUSH
                                             н
  0412
           E5
                                    PUSH
  0413
           E5
                                    PUSH
  0414
           E5
                                    PUSH
                                                      ; 40
  0415
           ΕB
                                    XCHQ
  0416
           F9
                                    SPHL
  0417
           FB
                           BSRTN:
                                    ΕI
  0418
           C9
                                    RET
                           ; (FUNCTION) delete
                                             A, SPC
  0419
           3E 20
                                    MVI
                           DEL:
  041B
           CD O6CB
                                    CALL
                                             STSP
                                                      store space
  041E
           AF
                                    XRA
                                             A
                                                      ; do back space
                           PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
                                                      17
  041F
                           ; (FUNCTION) back space
                                    CNZ
                                             CHKCM
  041F
           C4 06C1
                           BS:
                                                      check graphics mode
  0422
           F3
                           BS1:
                                    DI
  0423
           05
                                    DCR
                                                      ;cursor-1
  0424
           F2
              0417
                                    JP
                                             BSRTN
                                                      ; not 1st column
  0427
           04
                                    INR
  0428
           FB
                                    ΕI
  0429
           3A 3FEF
                                    LDA
                                             GECNTL
  042C
           B7
                                    ORA
                                             Α
                                                      graphics mode?
 042D
           CO
                                    RNZ
                                                      :defeat wrap arround
  042E
                                    CALL
           CD 0451
                                             UCUR 1
                                                      ; up cursor one row
  0431
           CB
                                    RΖ
                                                      ; crow=frow?
                                             B, 79
  0432
           06 4F
                                    MVI
                                                      ; set cursor to last col
  0434
           D3 01
                           BELL:
                                    OUT
                                             BELPRT
  0436
           C9
                                    RET
                           ; (FUNCTION) forward cursor
  0437
           CD 06C1
                                    CALL
                                             CHKGM
                           FS:
                                                      ; check graphics mode
           3E 4F
                                    MVI
  043A
                                             A, 79
  0430
                                    CMP
           B8
                                             R
                                                      ; last column?
  043D
                                             MIDCHR
           C2 0387
                                    JNZ
                                                      inot last column
  0440
           3A 3FEF
                                    LDA
                                             GECNTL
  0443
           В7
                                    ORA
                                                      graphics mode?
  0444
           CO
                                    RNZ
                                                      defeat wrap arround
  0445
           CD 0463
                                    CALL
                                             DCUR1
                                                      down cursor one row
  0448
           C8
                                    RΖ
                                                      ;crow=lrow?
  0449
           06 00
                                    MVI
                                             B, O
                                                      ; set cursor to 1st col
                                             BELPRT
  044B
           D3 01
                                    DUT
  044D
           C9
                                    RET
                           ; {FUNCTION} up
                                            cursor one row
 044E
           CD 06C1
                           UPCUR:
                                    CALL
                                             CHKCM
                                                      ; check graphics mode
  0451
           11 3FFA
                           UCUR1:
                                    LXI
                                             D, CROW
  0454
           2A 3FFE
                                    LHLD
                                             FROW
  0457
           1A
                                    LDAX
                                             D
  0458
           24
                                    INR
                                                      ; hl=row wrap arround tbl
  0459
           ВD
                                    CMP
                                                      ; crow=frow?
  045A
           C2 04A7
                                    JNZ
                                             $4
  045D
           D3 01
                                    DUT
                                             BELPRT
                                                     ;crow=frow, ring bell
  045F
           C9
                                    RET
                           ;{FUNCTION} down cursor one row
  0460
           CD 06C1
                           DWNCUR: CALL
                                             CHKGM
                                                      ;check graphics mode
  0463
              3FFA
                           DCUR1:
                                    LXI
                                             D. CROW
  0466
           2A
              3FFC
                                    LHLD
                                             LROW
  0469
           1A
                                    LDAX
                                                      ; CTOW
           24
                                    INR
  046A
                                             н
                                                      ;hl=row wrap arroud tbl
  046B
           ВD
                                    CMP
                                                      ;crow=lrow?
  046C
           C2
              04A9
                                    JNZ
                                             $5
           DЗ
  046F
              01
                                    DUT
                                             BELPRT
                                                      ;crow=lrow, ring bell
  0471
           C9
                                    RET
                           PAGE
STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
                                                      18
CRT801
  0472
                           ; {FUNCTION} roll up
  0472
              3FFA
                           ROLUP:
                                    LXI
                                             D, CROW
  0475
           2A
              3FFE
                                    LHLD
                                             FROW
  0478
           1A
                                    LDAX
                                             D
  0479
           24
                                    INR
                                             н
                                                      ;hl≖row wrap arround tbl
  047A
           BD
                                    CMP
                                                      ; crow=frow?
  047B
           7E
                                    MOV
                                             A, M
                                                      inext row
  0470
           F3
                                    DI
              3FFE
                                             FROW
  047D
           32
                                    STA
                                                      ; frow+1
                                    JNZ
  0480
           C2 0484
                                             RUNEG
```

```
0483
                                   STAX
                                            D
                                                     ; crow+1
  0484
           ΕB
                           RUNEO:
                                   XCHG
                                                     ; d=1, h=3Fh
  0485
           2E
                                   MVI
                                            L, low LROW
  0487
           5E
                                   MOV
                                            E, M
                                                     ; de=row wrap arround tbl
  0488
                                   LDAX
           1A
                                            D
                                                     , next row
  0489
           77
                                   MOV
                                            M, A
                                                     ; lrow+1
  048A
           FB
                                   ΕI
  048B
           0.9
                                   RET
                           ; {FUNCTION} roll down
  0480
           11 3FFA
                          ROLDWN: LXI
                                            D, CROW
  048F
           3A 3FFC
                                   LDA
                                            LROW
  0492
           D6 04
                                   SUI
                                            4
                                                     ; up one row
           6F
  0494
                                   MOV
  0495
           26
              01
                                   MVI
                                            H, 1
                                                     ; hl=row wrap arround tbl
  0497
                                   LDAX
                                            D
           1 A
                                                     : CTOW
  0498
           D6 04
                                   SUI
                                            4
  049A
           BD
                                   CMF
                                                     ; crow=lrow?
  049B
           7E
                                   MUV
                                            A, M
                                                     ; up one row
  0490
           F3
                                   DI
  049D
           32 3FFC
                                   STA
                                            LROW
                                                     ; lrow-1
  04A0
           C2 04A4
                                    JNZ
                                            RDNEG
  04A3
                                   STAX
                                            D
                                                     ; crow-1
  04A4
           1E FE
                          RDNEQ:
                                   MVI
                                            E, low FROW
  04A6
                                   LDAX
                                            D
           1 A
  04A7
           D6
                           $4:
                                   SUI
  04A9
           6F
                           $5
                                   MOV
                                                     ;hl=row wrap arround tbl
  04AA
           7E
                                   MOV
                                            A, M
  04AB
           12
                                   STAX
                                                     : frow-1
  04AC
           FB
                                   ΕI
  04AD
           C9
                                   RET
                           ; {FUNCTION} enable cursor, unlock keyboard
           AF
  04AE
                          CURULK: XRA
  04AF
           32 3FEE
                                   STA
                                            KBDLCK
                                                     ; unlock keyboard
  04B2
                                   CMA
                                                     ; enable cursor
  04B3
           C3 001B
                                    JMP
                                            DICUR
                           ; {FUNCTION}
                                       lock keyboard
                                            KBDLCK ;lock keyboard
  04B6
           32 3FEE
                          KBLK:
                                   STA
  0489
                                   RET
                          PAGE
STARPLEX MACRO-ASSEMBLER V2.0
                                            PAGE
                                                     19
CRT801
  O4BA
                           ; {FUNCTION} delete rest of page
  O4BA
           3A 3FFA
                          DRTPG:
                                   LDA
                                            CROW
  O4BD
           CD 04E9
                                   CALL
                                            CTLRW2 ; clear crow+1 to 1row
                           : (FUNCTION)
                                        delete rest of line
 04C0
           CD 0171
                          DRTLN:
                                   CALL
                                            DFCLGC
                                                     gget cursor loc and diff
  04C3
           57
                                   MOV
                                            D, A
                                                     ; save
  04C4
           ЗА
              3F20
                                   LDA
                                            FBQ
  04C7
                           DRLLP:
                                   MOV
                                            M, A
           77
                                                     store space/attribute
  0408
           23
                                   INX
                                            н
  0409
           15
                                   DCR
                                            D
  04CA
           C2 04C7
                                   JNZ
                                            DRLLP
                                                     ;until end of line
 O4CD
           C9
                                   RET
                           (FUNCTION) clear screen
 04CE
           CD OABC
                          CLRSCN: CALL
                                            DEGRPH
                                                    ;defeat graphics mode
 04D1
           2A 3FFE
                                   LHLD
                                            FROW
  04D4
           7D
                                   MOV
                                            A, L
 04D5
           CD 04E6
                                   CALL
                                            CTLRW1
                                                     ; clear frow to lrow
                          ; (FUNCTION) home cursor
 04DB
          3A 3FFE
                          HOMCUR: LDA
                                            FROW
 O4DB
          32 3FFA
                                   STA
                                            CROW
                                                     ;crow=frow
 04DF
          06 00
                          ZROCUR: MVI
                                            B, O
                                                     ; set cursor to 1st col
 04F0
          69
                                   RET
                          ; CLEAR TO LAST ROW
           16 01
 04E1
                          CLRWLP: MVI
                                            D, 1
 04E3
           5F
                                   MOV
                                            E, A
                                                     ;de=row wrap arround tbl
  04E4
                                   LDAX
                                            D
           1A
                                                     ; next row
          6F
  04E5
                                   MOV
                                            L, A
  04E6
           CD O3DE
                          CTLRW1:
                                            CLRROW
                                   CALL
                                                     clear whole rou
                          CTLRW2:
 04F9
          2A 3FFC
                                   LHLD
                                            LROW
 04EC
                                   CMP
                                                     :row=lrow?
          BD
  04ED
          C2 04E1
                                   JNZ
                                            CLRWLP
                                                     ;until last row
  04F0
           C9
                                   RET
                          ; {FUNCTION}
                                        foreground follows
 04F1
                                            D, 02020h; foreground spaces
           11 2020
                          FGNDF: LXI
 04F4
          C3 04FA
                                   JMP
                                            LDFGD
```

```
; {FUNCTION} background follows
  04F7
           11 AOAO
                           BGNDF:
                                            D. OAOAOh; background spaces
                                   LXI
  04FA
           21 0000
                           LDFGD:
                                   LXI
                                            H. O
  04FD
           39
                                            SP
                                   DAD
  04FE
           ΕB
                                   XCHG
           31 3F50
                                             SP, DMYROW+80
  04FF
                                   LXI
  0502
           C3 03EC
                                    JMP
                                            PUSHSP : store in dummy row
                           PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                            PAGE
                                                      20
CRT801
  0505
                           ; {FUNCTION} insert a line
  0505
           CD 0590
                           INSLNE: CALL
                                            CRLR
                                                      ; calc crow/lrow diff
  0508
           21 3FFA
73
                                   LXI
                                            H, CROW
  050B
                                   MUV
                                            M, E
                                                      ;set crow=lrow
           C2 054B
                                            MOVDWN
  050C
                                    JN7
                                                     ; move row contents
                                            DRWZCU
                                                      ;else, del lrow/zero cur
  050F
           C3 058C
                                    JMP
                           ;{FUNCTION} strip off a line
  0512
           CD 0590
                           STOFLNE: CALL
                                             CRLR
                                                      ; get crow/lrow diff
  0515
           CA 058C
                                             DRWZCU
                                                      idel lrow/zero cursor
  0518
                                   PUSH
           E5
                           SLNERG:
                                                      ; else do move
  0519
           21 3FE7
                                   LXI
                                             H, CPYCTL
  051C
           36 00
                                   MVI
                                            M, O
                                                      ;copy upward
  051E
                                   CALL
                                            MOVROW
           CD 0550
                                                      ; move row contents
                                   PUP
  0521
           E1
                                                      get original crow
                                            CROW
  0522
           22 3FFA
                                   SHLD
                                                      ; back to crow
  0525
           C9
                                    RFT
                           ; {FUNCTION} insert/strip off line with range
  0526
           2A 3FFA
                           ISLRG:
                                   LHLD
                                             CROW
  0529
           3A 3FA3
                                   LDA
                                            LINP
                                                      read 2nd parameter
  052C
           ЗD
                                    DCR
                                             03Fh
  052D
           E6 3F
                                   ANI
                                                      :40/7Fh offset to 0/3Fh
  052F
           FE 38
                                    CPI
                                             038h
  0531
                                   RNC
           DO
                                                      ; error
  0532
           FE 17
                                    CPI
                                            017b
  0534
           DA 0530
                                    JC
                                             ISNPA
  0537
           FE 20
                                   CPI
                                             020h
  0539
           D8
                                   RC
                                                      ; error
  053A
           D6 09
                                    SUI
                                             9
  053C
           зс
                           ISNPA:
                                    INR
                                             A
  053D
                                    MOV
                                            D, A
           57
  053E
           3A 3FA4
                                   LDA
                                            LINP+1
                                                      ;read 1st parameter
                                             "5"
  0541
           FE 53
                                    CPI
                                                      strip off?
  0543
           7A
                                    MOV
                                             A, D
                                                     ; do strip off line
  0544
           CA 0518
                                             SLNERG
                                    JΖ
                                                      offset row by para
           CD 05C1
                                             IRWOS
  0547
                           ILNERG:
                                   CALL
  054A
           7A
                                   MOV
                                             A, D
                                                      return para
                                             H, CPYCTL
  054B
           21 3FE7
                           MOVDUN:
                                   LXI
  054E
           36
              04
                                    MVI
                                             M, 4
                                                      ; copy downward
                           , MOVE ROW CONTENTS, UP/DOWN CNTL BY CPYCTL
  0550
                           MOVROW: PUSH
                                             PSW
           F5
                                                      save row count
  0551
           2A 3FFA
                                    LHLD
                                             CROW
  0554
                                    MOV
           5E
                                             E, M
  0555
           23
                                    INX
                                             н
  0556
           56
1B
                                    MOV
                                             D. M
  0557
                                    DCX
                                             D
                                                      ; crow end
  0558
                                    PUSH
           D5
                                             D
                                                      : SAVE
                                             H, CPYCTL; direction control
  0559
           21
              3FE7
                                    LXI
  0550
           11
              3FFA
                                    LXI
                                             D. CROW
                                    LDAX
  055F
           1A
                                             D
                                                      read crow
  0560
           96
                                    SUR
                                             M
                                                      ; direction cntl
                           PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
                                                      21
CRT801
  0561
                                    MOV
  0561
           6F
                                             L, A
  0562
           26 01
                                    MVI
                                             H, 1
                                                      ;hl=row wrap arround tbl
  0564
           7E
                                    MOV
                                             A, M
                                                      ;lookup +/- one row
  0565
           12
                                    STAX
                                                      supdate crow
  0566
           6F
                                    MOV
                                             L, A
  0567
           25
                                    DCR
                                                      ; hl=row start table
  0568
           5E
                                    MOV
                                             E, M
  0569
           23
                                    TNX
                                             н
  056A
           56
                                    MOV
                                             D, M
  05AB
           18
                                    DCX
                                             D
                                                      ;+/- row end
  056C
           E1
                                    PUB
                                             н
                                                      irth current row last loc
  056D
           06 10
                                    MVI
                                             B,80/5
                                                      ; copy 80 characters
  056F
           1A
                           CPLP:
                                    LDAX
                                             D
                                                      read
  0570
           77
                                    MOV
                                             M, A
                                                      copy
                                                      inext byte
  0571
           2B
                                    DCX
                                             н
  0572
           1B
                                    DCX
                                             D
                                                      inext byte
                                                      ido 5 times for speed
  0573
                                    LDAX
                                             D
           1 A
           77
                                    MOV
  0574
                                             M. A
```

```
0575
                                   DCX
          2B
                                            н
 0576
          1 B
                                   DCX
                                            D
                                   I DAX
 0577
          1 A
                                            D
                                                     , 3
 0578
          77
                                   MUA
                                            M, A
 0579
          28
                                   DCX
                                            н
 057A
          1 B
                                   DCX
                                            D
 057B
                                   LDAX
                                            D
          1A
                                                     14
 057C
          77
                                   MOV
                                            M, A
 057D
          2B
                                   DCX
                                            н
 057E
                                   DCX
                                            D
          1 R
 057F
                                   LDAX
                                            D
                                                     ; 5
          1A
          77
2B
                                   MOV
 0580
                                            M. A
 0581
                                   DCX
                                            н
 0582
          1B
                                   DCX
                                            D
 0583
          05
                                   DCR
                                            В
 0584
          C2 056F
                                   JNZ
                                            CPLP
                                                     ;finish 80 bytes?
 0587
          F1
                                   POP
                                            PSW
                                                     ; row count
 0588
                                   DCR
          ЗD
 0589
                                            MOVROW
          C2 0550
                                   JNZ
                                                     ; next row
 058C
          47
                          DRWZCU:
                                  MOV
                                                     ; zero cursor
                                            B, A
 058D
          C3 O3DB
                                            DCROW
                                                     and delete cursor row
                                   JMP
                          CALCULATE ROW DIFFERENCE
 0590
          2A 3FFA
                                   LHLD
                          CRLR:
                                            CROW
                                                     ; calc crow to lrow
 0593
          3A 3FFC
                                   LDA
                                            LROW
 0596
          5F
                          FRCR:
                                   MOV
                                            E, A
 0597
          95
                                   SUB
                                                     ; get the difference
 0598
          D2 05A0
                                   JNC
                                            $2
                                                     within range
 059B
          3E 60
                          $D2:
                                   MVI
                                            A, RWRG
                                                     ; over range
 059D
          83
                                   ADD
                                            Ε
 059E
          95
                                   SUB
 059F
          87
                                   DRA
                                                     ; clear carru
          1 F
                          $2.
                                   RAR
                                                     ; row diff /2
 05A0
 05A1
          C9
                                   RET
                          PAGE
STARPLEX MACRO-ASSEMBLER V2. 0
                                            PAGE
                                                     22
 05A2
                          ;{FUNCTION} address cursor
                                           LINP
                          ADDCUR: LHLD
 05A2
          2A 3FA3
                                                     ;read leadin parameter
 05A5
          7C
                                   MOV
                                            A, H
 05A6
          11 5010
                          CALCX:
                                   LXI
                                            D, 05010h; calc x coordinate
 05A9
                                   CMP
          BA
                                            CX4FD
 05AA
          DA 05B3
                                                     ;00/4Fh=loc 0/79
                                   JC
 05AD
          92
                                   SUB
                                            D
                                                     ;50/7Fh offset to 0/2F
 05AE
          BB
                                   CMP
                                            Ε
                                                     ;50/5Fh offset to 0/15;60/7Fh offset to 0/31
 05AF
          DA 05B3
                                   JC
                                            CX4FD
                                   SUB
 05B2
          93
                                            Ε
 05B3
          47
                         CX4FD:
                                   MUA
                                            B, A
                                                     ; then set cursor
 05B4
          3E 1F
                          CALCY:
                                   MUI
                                            A, O1Fh
                                                     ; 0/1F, 20/3F, 40/5F, 60/7Fh
 05B6
          A5
                                   ANA
 05B7
          FE 18
                                   CPI
                                            018h
                                                     ; offset to 00/1Fh
 0589
          DA OSBE
                                   JC
                                            CY17D
                                                     ;00/17h=row 0/23
 O5BC
          D6 18
                                   SUI
                                            018h
                                                     ;18/1Fh=row 0/7
                                   LHLD
 05BE
          2A 3FFE
                         CY17D:
                                            FROW
                                                     ; offset first row
 05C1
          07
                          IRWOS:
                                   RLC
                                                     ; diff*2, msb=0
                                   ADD
 05C2
          85
                                                     ; frow+offset
                                            ROSFFU
 05C3
          DA OSCB
                                   JC
                                                     : DEFh
                                            10w RR48+1
          FE E1
                                   CPI
 0506
          DA OSCD
 0508
                                   JC
                                            ROSEOD
                                                    ;less than EOh, ok
                          ROSFFU: SUI
 O5CB
          D6 60
                                            RWRG
                                                     ;row range
 O5CD
          32 3FFA
                          ROSEOD:
                                   STA
                                            CROW
                                                     then update crow
 05D0
          C9
                                   RET
                          ; (FUNCTION) read cursor
 05D1
          CD OSEO
                          RDCUR:
                                   CALL
                                            RDX
                                                     read cursor x coord
          CD 006D
                                   CALL
                                            WTACEA
 0504
                                                     surite to ace
 05D7
          CD 05E7
                                   CALL
                                            RDY
                                                     read cursor y coord
 05DA
          CD 006D
                                   CALL
                                            WTACEA
                                                     swrite to ace
 05DD
          C3 074A
                                   JMP
                                            CRACE
                                                     cr for termination
 05E0
                         RDX:
                                   MOV
          78
                                            A, B
 05E1
                                   CPI
                                            020h
                                                     ; if O/1Fh add offset
          FE 20
                                   RNC
                                                     ;20/4Fh=cursor loc 32/79
 05E3
          DO
 05E4
                                   ADI
                                            060h
                                                     :60/7Fh=cursor loc 0/31
          C6 60
                                   RET
 05FA
          C9
```

```
05E7
           2A 3FFE
                           RDY:
                                    LHLD
                                             FROW
  05EA
           3A 3FFA
                                    LDA
                                             CROW
  OSED
           CD 0596
                                    CALL
                                             FRCR
                                                       ; calc frow/crow diff
  05F0
           C6 60
                                    TOA
                                             060h
                                                      :60/77h=row 0/23
  05F2
           ro
                                    RET
                           PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
                                                      23
  05F3
                           ; (FUNCTION)
                                        next page
  05F3
           16 30
                           NPAGE:
                                    MVI
                                             D. 030h
  05F5
           21
              3FFA
                                    LXI
                                             H, CROW
  05F8
           F3
                                    DΙ
  05F9
           7E
                           NPLP:
                                    MOV
                                              A, M
  05FA
           FE
              B1
                                    CPI
                                             OB1h
  05FC
              0601
                                    JC
                                             NPLT
           DA
                                                      ; a< B1,82-B0h
  05FF
           92
                                    SUB
                                             D
                                                      ; a>=B1, B2-E0h
  0600
           92
                                    SUB
                                             n
  0601
                           NPLT:
           82
                                    ADD
                                             D
  0602
           77
                                    MOV
                                              M, A
  0603
           20
                                    INR
                                                      ido crow/lrow/frow
  0604
           20
                                    INR
  0605
           FA
              05F9
                                             NPLP
                                    JM
                                                      ; if pass frow, end
  8040
           FB
                                    ΕI
  0609
           C9
                                    RET
                           ; (FUNCTION) tab
  060A
           2A 3FFA
                                    LHLD
                                             CROW
                           TAR ·
  0600
           E5
                                    PUSH
                                                      ; save crow
  060E
           CD 0667
                                    CALL
                                             SCATT
  0611
           13
                           TDAOSP:
                                    INX
                                             D
                                                      ; next character
  0612
           2D
                                    DCR
                                                      ; end of row?
  0613
           CC
              067A
                                    СZ
                                             DRCFL
                                                      idown one row, get 1st loc
                                    LDAX
  0616
           1A
                                             D
                                                      read character
  0617
           84
                                    ADD
                                             н
                                                      ;check attribute
                                    JM
                                             TSATT
  0618
           FA 0635
                                                      diff, find same attrib
  061B
           FE 20
                                    CPI
                                             SPC
                                                      :space?
  061D
           C2 0611
                                    JN7
                                             TDAOSP
                                                      ;loop until space
                                                      inext character
  0620
           13
                           TSANSP:
                                    INX
                                             D
  0621
           2D
                                    DCR
                                                      iend of row?
  0622
           CC
              067A
                                    CZ
                                             DRCFL
                                                      down one row, get 1st loc
  0625
           1A
                                    LDAX
                                             D
                                                      read character
                                                      ;check attribute
;diff, find same attrib
           84
                                    ADD
  0626
                                             н
  0627
           FA 0635
                                    JM
                                              TSATT
  062A
           FE 20
                                    CPI
                                             SPC
                                                      inon space?
  0950
                                             TSANSP
           CA
              0620
                                    JZ
                                                      ;loop until non space
  062F
                           TMCUR:
           Di
                                    PDP
                                             D
                                                      remove saved crow
  0630
                                    MVI
           3E 50
                                             A, 80
  0632
           95
                                    SUB
                                                      ; calc cursor location
  0633
           47
                                    MOV
                                             B, A
                                                      ; move cursor
  0634
           C9
                                    RET
  0635
           13
                           TSATT:
                                    INX
                                             D
                                                      inext character
  0636
           2D
                                    DCR
                                                      iend of row?
                                             DRCFL
  0637
           CC
              067A
                                    CZ
                                                      idown one rowiget 1st loc
  063A
                                    LDAX
           1A
                                             D
                                                      read character
  063B
           84
                                    ADD
                                             н
                                                      ;check attribute
           FA 0635
                                             TEATT
  0630
                                    JM
                                                      ; loop until same attrib
  063F
           C3 062F
                                    JMP
                                             TMCUR
                                                      imove cursor
                           PAGE
STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
                                                      24
CRT801
  0642
                           ;{FUNCTION} clear fore/background to space
  0642
           2A 3FFA
                                             CROW
                           CFB:
                                    LHLD
  0645
           24
                                    TNR
  0646
           E5
                                    PUSH
                                                      save
  0647
              0667
                                    CALL
                                              SCATT
  064A
                           CFBLP:
                                    LDAX
                                             D
                                                       read character
  064B
           84
                                    ADD
                                                      ;test attribute
  064C
           FA
              0653
                                    JM
                                             CFBDIF
                                                      diff attrib
  064F
           3E 20
                                    MVI
                                                      ; if same attrib.
                                              A, SPC
  0651
           B4
                                    DRA
                                              н
                                                      ; put a space
  0652
           12
                                    STAX
                                             D
  0453
           13
                           CFBDIF:
                                    INX
                                             D
                                                      ; next character
  0654
           2D
                                    DCR
                                                      :character counter-1
  0655
           C2
              064A
                                     JNZ
                                              CFBLP
                                                       ; ùntil finish 80 char
  0658
           E1
                                    POP
                                                       saved crow
  0659
              3FFC
                                    LDA
                                             LROW
  065C
           BD
                                    CMP
                                                       ; row=lrow?
  065D
           CB
                                    RΖ
                                                      ino more
  065E
           6E
                                    MOV
                                              L, M
                                                      ; else next row
  065F
           E5
                                    PUSH
                                             н
                                                       ; save
                                              $3
  0660
           CD
              0481
                                    CALL
                                    JMP
                                             CFBLP
  0663
           C3
              064A
  0666
           C9
                                    RET
```

```
SET UP CHAR COUNTER AND ATTRIB
  0667
           CD 0174
                           SCATT:
                                    CALL
                                             CURLOC ; get cursor location
  066A
           ΕB
                                    XCHG
                                                      ; put in de
  066B
           21 8050
                                    LXI
                                             H,08050h; mask/char count
           ЗА
              3F20
                                    LDA
                                            FBG
  066E
  0671
           A4
                                    ANA
                                    MOV
  0672
           67
                                            H, A
           22 3FA5
  0673
                                    SHLD
                                            LINP+2 ; save count, attrib
                                    MOV
  0676
           7D
                                             A, L
           90
  0677
                                    SUR
                                             В
                                                      get cur to end diff
  067B
           6F
                                    MOV
                                                      ; put in 1
  0679
           0.9
                                    RET
                           DOWN ONE ROW AND GET ADDR ON 1ST COLUMN
  067A
           CD 0463
                                   CALL
                                            DCUR1
                                                      idown cursor one row
  067D
           CA 0033
                                    JZ
                                             TABSTP
                                                      ;crow=lrow, no tab
                                    MOV
  0680
           ΔE
                                            L.M.
                                                      inext row
           25
                                    DCR
  0681
                           $3:
           2R
                                    DCX
  0682
                           $1 ·
  0683
           56
                                    MOU
                                             D, M
                                                      ; addr high
  0684
           28
                                    DCX
  0685
           5E
                                    MOV
                                             E. M
                                                      addr low
  0686
           2A 3FA5
                                    LHLD
                                            LINP+2
                                                      ; count and attrib
  0689
           C9
                                    RET
                           PAGE
 STARPLEX MACRO-ASSEMBLER V2.0
                                            PAGE
                                                      25
  068A
                           ; {FUNCTION} graphics
  068A
           EARE AE
                           GRAPH:
                                    LDA
                                            LINP
                                                      ;read leadin parameter
  068D
           21 107E
                           LGPARA:
                                    LXI
                                             H, 0107Eh
  0690
           ЗD
                                    DCR
  0691
           E6 3F
                                    ANI
                                             03Fh
  0693
           ВC
                                    CMP
                                                      ; h=010h
                                            н
                                             $G1
                                                      ;"A" to
;delete
  0694
           DA O6AD
                                    JC
  0697
           FE 3E
                                    CPI
                                             03Eh
  0699
           CA 06B2
                                    JΖ
                                             $G3
           94
  0690
                                    SUR
                                                      : h=010h
                                             н
           FF OF
                                    CPI
                                             0Fh
  069D
                                                      :space?
  069F
           CA 06B2
                                    JZ
                                             $G3
                                                      ; space
  06A2
           BC
                                    CMP
                                                      ; h=010h
  CA40
           DA 06AC
                                    JC
                                             $G2
                                                      ;> "Q"
           FE 20
                                    CPI
                                             020h
  06A6
                                                      ;"a" to "p"
;set 1 to 7Fh
;L=7Eh or 7Fh
  06AB
           DA O6AD
                                    JC
                                             $G1
  06AB
           20
                                    INR
                                             L
                           $G2:
                                    MOV
  06AC
           7D
                                             A. L
           CD 06D0
                                    CALL
                                             STSCN
  06AD
                           $G1:
                                                      ; put sumbol to screen
  06B0
                                    ADI
           C6 1E
                                             01Eh
  06B2
           D6 1E
                           $G3:
                                    SUI
                                             01Eh
  06B4
           32 3FF3
                                    STA
                                             GSYMBL ; for non/destructive move
  06B7
           3E 80
                           ENGRPH: MVI
                                             A, 080h
  06B9
           C3 O4BD
                                    JMP
                                             DEGRPH+1
                           ;{FUNCTION} defeat graphics
  O6BC
           ΑF
                           DEGRPH: XRA
           32 3FEF
                                             GECNTL
  OARD
                                    STA
  0.00
           C9
                                    RET
                           CHECK GRAPHICS MODE AND PUT SYMBOL TO SCREEN
  06C1
           3A 3FEF
                           CHKGM:
                                    LDA
                                             GECNTL
  06C4
           B7
                                    ORA
                                                      graphics mode?
  04C5
           CB
                                    RZ
                                                      ;no, rtn to func
  0606
           3A 3FF3
                                    LDA
                                             GSYMBL
  0609
           R7
                                    DRA
                                             Α
                                                      ; non destructive move?
  OACA
          FR
                                    RM
                                                      ; ues
           21 3F20
                           STSP:
                                             H. FRG
  OACB
                                    LXI
  06CE
           ΑE
                                    XRA
                                             М
                                                      get attribute
  06CF
           AD
                                    XRA
                                                      remove space code
  06D0
           CD 0174
                           STSCN:
                                    CALL
                                             CURLOC
           77
                                    MOV
  06D3
                                             M, A
                                                      ; write to screen
  06D4
           C9
                                    RET
                           PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
                                                      26
CRTROI
  06D5
                           PUT GRAPHIC MENU TO SCREEN (LOCAL)
  06D5
           CD 070C
                           PGM:
                                    CALL
                                             RUADD
  BUAD
           CD 06F3
                                    CALL
                                             PRESVM
                                                     ;print ascii A/Q
           CD 06F3
                                    CALL
  06DB
                                             P38SYM
                                                     ;print ascii a/q
```

```
CD 070C
                                    CALL
                                             RUADD
  OADE
  06E1
                                              P32SYM
           CD 0700
                                    CALL
                                                      print ascii Oh/Fh
  06E4
           F6 7E
                                    ORI
                                              07Eh
                                                       ;print ascii 7Eh
  06E6
           CD 06F7
                                     CALL
                                             P6SYM
                                                       ; 4 spaces
  06E9
           EE 30
                                     XRI
                                              030h
                                                       ;print ascii 10/1Fh
  06EB
           CD 0700
                                     CALL
                                              P32SYM
                                    ORI
                                              07Fh
  06EE
           F6 7F
                                                       ;print ascii 7Fh
  06F0
           C3 06F7
                                     JMP
                                             P6SYM
                                                       ,4 spaces
  06F3
           F6 41
                           P38SYM:
                                    ORI
                                              041h
                                                       ; change symbol
  06F5
           16 10
                                    MVI
                                              D. 16
                                                       counter
  06F7
           14
                           PASVM:
                                    INR
                                              D
  OAFR
           CD 0702
                                             PGMI P
                                    CALL
  OAFB
           16 04
                           P4SP:
                                    MVI
                                             D. 4
           C3 04C4
                                             DRLLP-3 ; put 4 spaces
  06FD
                                    JMP
  0700
                           P32SYM: MVI
           16 10
                                              D. 16
                                                       print 32 symbols
  0702
           77
                           PGMLP:
                                    MOV
                                             M, A
           23
  0703
                                    INX
  0704
                                    MOV
                                             M, E
                                                       ; FBG
           23
  0705
                                     TNY
                                             н
  0706
           30
                                     TNR
                                              Δ
                                                       inext symbol
  0707
           15
                                    DCR
                                              D
           C2 0702
C9
  0708
                                     JNZ
                                             PGMLP
  070B
                                    RET
                                             ROLUP
  070C
           CD 0472
                           RUADD:
                                    CALL
                                                       ; up one row
  070F
           26 00
                                    MVI
                                             H, O
  0711
                                    MOV
           6F
                                                       ; hl=lrow
                                             L, A
  0712
           CD 0682
                                    CALL
                                                       ; lrow 1st loc
                                              $1
  0715
           ΕB
                                    XCHQ
                                             P4SP
  0716
           CD O6FB
                                    CALL.
                                                       ; put 4 spaces
  0719
           5F
                                    MOV
                                             E, A
                                                       ; FBQ
  071A
           E6 80
                                    ANI
                                             080h
                                                       get attribute
  071C
           C9
                                    RET
                           PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                             PAGE
CRTB01
  071D
                            ;{FUNCTION} transmit a line
  071D
           06 00
                           SNDLNE: MVI
                                              B, O
                                                       ; set cursor to 1st loc
  071F
           CD 0174
                                    CALL
                                              CURLOC
                                                       ; get row start
  0722
           E5
                                    PUSH
                                                       ; save row start
                                              D, 79
  0723
           11 004F
                                    LXI
                                                       ; find row end
           19
                                                       ;hl≖row end, clear carry
  0726
                                    DAD
  0727
                                     MUI
                                              D, 040h
                                                       ;rotated space
           16 40
  0729
           7E
                           LENDLP:
                                    MOV
                                              A/M
                                                       read char
  072A
           17
                                     RAL
                                                       ; mask out msb
  072B
                                    XRA
                                              n
                                                       ; space? , clear carry
                                                       until find a non-space
  0720
           C2 0734
                                     JNZ
                                              LNSP
  072F
           2B
                                     DCX
  0730
                                    DCR
           1 D
                                              LENDLP
  0731
           C2 0729
                                     JNZ
                                                       repeat loop
  0734
                           LNSP
                                     POP
                                                       ; hl=row start again
           E1
                           SNDLP
                                              D, M
  0735
                                    MOV
                                                       iread character
           56
  0736
           3E 60
                                    MVI
                                              A, 060h
                                                       ; screen all cntl codes
  0738
           A2
                                     ΔΝΔ
                                              n
                                              SNCNTL
           C2 073E
                                                       ;not control code
;cntl code,send "*" instead
  0739
                                     JNZ
  073C
           16
              2A
                                     MVI
                                              D, "#"
  073E
           CD
              006E
                           SNCNTL:
                                     CALL
                                              WTACED
                                                       ; write to ace
  0741
           7E
                                     MOV
                                              A, M
                                                       read char again
  0742
           EE
              80
                                     XRI
                                              OBOh
                                                       ; invert attribute
  0744
           77
                                     MOV
                                              M, A
                                                       ;store back
  0745
           23
                                     INX
                                              н
                                                       ; next character
  0746
                                     DCR
           1 D
  0747
           F2 0735
                                     JP
                                              SNDI P
                                                       juntil end of line
  074A
           CD 006B
                           CRACE:
                                    CALL
                                              SNDCR
                                                       ; send or for termination
  074D
           ЗА
               3FF1
                                    LDA
                                              LOCLM
  0750
           B7
                                     ORA
                                                       :local?
  0751
           CB
                                     RΖ
                                                       ;remote,no time delay
                                              $DLY
  0752
           CD 075E
                           $D3:
                                     CALL
                                                       ; do delau
  0755
                                     DCR
                                                       id was ODh
           15
                                              D
                                              $D3
  0756
           C2 0752
                                     JNZ-
                                              BELPRT
                                     CUT
  0759
           D3 01
                                                       ; delay done, ring bell
                                     JMP
                                              DCUR1
  075B
           C3 0463
                                                       ;move cursor to next row
                                     PUSH
  075E
           E5
                            $DLY:
                                              н
  075F
           D5
                                     PUSH
                                              D
```

```
0760
                                   CALL
                                            LURD
           CD 07F0
                                                     ;lookup baud constant
  0763
           3E 1F
                                   MVI
                                            A, 01Fh
                                                     ; chg delay at high bauds
  0765
           ВЗ
                                   ORA
  0766
           5F
                                   MOV
                                            E, A
  0767
           CD 059B
                          $D1:
                                   CALL
                                            $D2
  076A
           1B
                                   DCX
                                            D
  076B
                                   DCR
                                            D
           15
  076C
                                   INR
                                            D
           14
  074D
           F2 0767
                                   JΡ
                                            $D1
  3770
                                   POP
          D1
                                            n
  0771
                                   POP
           E1
                                            н
  0772
           C9
                                   RET
                          PAGE
STARPLEX MACRO-ASSEMBLER V2. 0
                                            PAGE
                                                     28
CRT801
  0773
                          DISPLAY CURSOR LOCATION (LOCAL)
  0773
                          LRDCUR: CALL
           CD 05E7
                                            RDY
                                                     ;y coordinate
  0776
                                            LROW
           2A 3FFC
                                   LHLD
                                                     get print out loc
  0779
           5E
                                   MOV
                                            E, M
  077A
           23
                                   INX
                                            н
  077B
           56
                                   MOV
                                            D, M
  077C
           1 B
                                   DCX
                                                     ; lrow last location
                                            D
  077D
           12
                                   STAX
                                            D
                                                     ; put to screen
  077E
                                                     ; x coordinate
           CD OSEO
                                   CALL
                                            RDX
  0781
           1B
                                   DCX
                                            D
  0782
                                   STAX
                                                     : but to screen
           12
                                            n
  0783
           C9
                                   RET
                          SCALE (LOCAL)
  0784
                                            H, FROW
           21 3FFE
                          SCALE:
                                   LXI
  0787
           3A 3FFA
                                   LDA
                                            CROW
  078A
          BE
                                   CMP
                                                     ; frow=crow
  078B
          CC 048C
                                   CZ
                                            ROLDWN
                                                     ; if equ, roll down
  078E
           2A 3FFA
                                   LHLD
                                            CROW
                                                     get print out loc
  0791
                                   DCX
           2B
  0792
           28
                                   DCX
                                            н
           CD 0682
  0793
                                   CALL
                                            $1
  0796
          FR
                                   XCHG
                                                     ; hl=loc
                                            E, "1"
           1E 31
  0797
                                   MUI
           16 B1
  0799
                          SCLLP1: MVI
                                            D, "1"+080h
  079B
           3E BA
                                   MVI
                                            A, "9"+081h
  079D
           72
                          SCLLP2:
                                   MOV
                                            M, D
  079E
           14
                                            D
                                                     ;"1" to "9"
                                   INR
  079F
           23
                                   INX
                                            н
                                                     next location
  07A0
                                   CMP
                                            D
                                                     ; exceeding "9"?
          BA
          C2 079D
  07A1
                                            SCLLP2
                                   JNZ
                                            A, "9"
  07A4
          3F 39
                                   MUT
  07A6
                                            M, E
                                   MOU
           73
  07A7
                                                     ;"1" to "8"
           1C
                                   INR
                                            Ε
  07A8
           23
                                   INX
                                            н
                                                     next location
  07A9
          BB
                                   CMP
                                            Ε
                                                     ;exceeding "8"?
          C2 0799
  07AA
                                   JNZ
                                            SCLLP1
  O7AD
                                   RET
                          VERTICAL INTERRUPT CONTINUE
 07AE
                          VTSUB:
                                   DCX
           2B
                                                     ; VCALEN
                                            н
 07AF
07B0
           74
                                   MOU
                                            M, H
                                                     ;h<>O, enable VCAL routine
           2A 3FF8
                                   LHLD
                                            CUR
                                                     get cursor
                                                     ; write to DP8350
  07B3
           36 03
                                   MUT
                                            м, з
  07B5
           2A 3FF6
                                   LHLD
                                            TOP
                                                     ; top of page
  07B8
           36 02
                                   MVI
                                            M, 2
                                                     ; write to DP8350
  07BA
           D3 40
                                   OUT
                                            VERPRT
                                                     ;clr vert intr flip/flop
  07BC
           E1
                                   POP
  O7BD
          FB
                                   ΕI
  07BE
           C9
                                   RET
                          PAGE
STARPLEX MACRO-ASSEMBLER V2. 0
                                            PAGE
                                                     29
CRT801
  07BF
                          ; (FUNCTION) ace, auto line feed, upper/lower case
  07BF
          DB 40
                                            SETSW
                          ACESW:
                                   IN
                                                     read switch settings
  07C1
           E6 10
                                   ANI
                                            010h
  07C3
           32 3FF2
                                   STA
                                            AULF
                                                     ; set auto 1f flag
  0706
          DB 40
                                   TΝ
                                            SETSM
                                                     read switch again;
  0708
          E6 20
                                   ANI
                                            020h
  07CA
                                                     ;set u/l case flag
          C3 07D2
                                   JMP
                                            STUL
```

```
; INIT ACE, TOGGLE ULCASE (LOCAL)
07CD
         3A 3FF0
                         ATGUL:
                                   LDA
                                            ULCASE
07D0
         EE
            20
                                   XRI
                                            020h
                                                      ;toggle u/l case
07D2
            3FF0
                         STUL:
                                   STA
                                            ULCASE
07D5
         CD 07F0
                                   CALL
                                            LUBD
                                                      :lookup baud constant
07D8
                                   LXI
                                            H, ACECTL
             9003
                                   MUU
                                                     ;set DLAB
O7DB
         74
                                            M, H 🕔
         2E
            01
                                   MUT
O7DC
                                            L, 1
07DE
         72
                                   MOV
                                            M, D
                                                      set baud high
07DF
         28
                                   DCX
07E0
         73
                                   MOV
                                            M, E
                                                      set baud lou
07E1
         2E 03
                                   MVI
                                            L, 3
            02
                                   MVI
         36
                                            M. 2
                                                      :7 bit.1 stop bit
07F3
07E5
            3FF1
                                   LDA
                                            LOCKM
         ЗА
                                                     :local?
                                   INR
07E8
         30
                         EDACE:
07E9
         21
            9000
                                   LXI
                                            H, ACEDTA
07EC
         5E
                                   MOV
                                            E, M
                                                      remove ace input
07ED
         23
77
                                   INX
                                                      ACEITR mask
07EE
                                   MOV
                                            M, A
                                                      ;en/disable ace intr
07EF
         C9
                                   RET
         DB 40
07F0
                         LUBD:
                                   IN
                                            SETSW
                                                      ;lookup baud constant
07F2
         E6
            0E
                                   ANI
                                            OEh
07F4
                                   ADI
         CA
            FO
                         BADDR:
                                            low B110; add base addr
                                   MOV
07F6
         6F
                                            L, A
07F7
         26
            01
                                   MUT
                                            H, 1
07F9
         5E
                                   MOV
                                            E, M
                                                      get baud low
07FA
         23
                                   INX
                                   MOV
                                            D, M
07FB
         56
                                                      get baud high
         C9
                                   RET
07FC
                                            START
                                              PAGE
 STARPLEX MACRO-ASSEMBLER V2. 0
                                                        30
CRT801
Macros:
Symbols:
$1
         0682
                  $2
                            05A0
                                     $3
                                               0681
                                                        $4
                                                                 04A7
$5
         04A9
                  $D1
                            0767
                                     $D2
                                               059B
                                                        $D3
                                                                 0752
$DLY
         075E
                  $G1
                            06AD
                                     $G2
                                               06AC
                                                        $G3
                                                                 06B2
         0038
                  ACECTL
                            9003
                                     ACEDTA
                                               9000
                                                        ACEDUP
                                                                 0018
ACE
                  ACESTU
                                     ACESW
                                                        ADDCUR
         7001
                            9005
                                               07BF
                                                                 05A2
ACF I TR
                  AUI F
                            3FF2
                                               01F0
                                                        B1200
                                                                 01F4
ATCUL
         O7CD
                                     B110
                                                                 01FB
B19200
                  B2400
                                     B38400
                                              01FE
         01FC
                            01F6
                                                        B4800
B600
         01F2
                  B9600
                            01FA
                                     BADDR
                                               07F4
                                                        BELL
                                                                 0434
BELPRT
         0001
                  BENDF
                            04F7
                                     BS
                                               041F
                                                        BS1
                                                                 0422
BSRTN
         0417
                  CID
                            023A
                                     C7E
                                               0240
                                                        CALCX
                                                                 05A6
         05B4
                            0150
                                     CARRTN
                                              0389
                                                        CB
                                                                 0204
CALCY
                  CALJMP
CE
         020A
                  CFB
                            0642
                                     CFBDIF
                                               0653
                                                        CFBLP
                                                                 064A
                                                        CJMP
                                                                 0158
CG
         020E
                  CHAR
                            0372
                                     CHKGM
                                               06C1
CLRROW
         O3DE
                  CLRSCN
                            04CE
                                     CLRWLP
                                               04E1
                                                        CMRTN
                                                                 0250
CPLP
                  CPYCTL
                            3FE7
                                     CQ
                                               0222
                                                        CR
                                                                 OOOD
         056F
CRACE
                  CRLR
                            0590
                                     CROW
                                               3FFA
                                                        CROWH
                                                                 3FFB
         074A
                                               022A
                                                                 3FF8
CTLRW1
         04E6
                  CTLRW2
                            04E9
                                     CU
                                                        CUR
                                     CURLOC
                                              0174
                                                        CURTMR
                                                                 3FEB
CUREN
         3FEC
                  CURH
                            3FF9
CURULK
         04AE
                  CX4FD
                            05B3
                                     CY17D
                                               05BE
                                                        DCROW
                                                                 O3DB
DCUR1
         0463
                  DEGRPH
                            06BC
                                     DEL
                                               0419
                                                        DFCLOC
                                                                 0171
DICMD
         03CE
                  DICUR
                            001B
                                     DMYROW
                                               3F00
                                                        DRCFL
                                                                 067A
                  DRTLN
                            04C0
                                     DRTPG
                                               04BA
                                                        DRWZCU
                                                                 058C
DRLLP
         04C7
DWNCUR
         0460
                  EDACE
                            07E8
                                     ENGRPH
                                               06B7
                                                        F1
                                                                 0A5F
                                               8472
                                                        F13
                                                                 848C
         84D8
                            85F3
                                     F12
F10
                  F11
F14
         84AE
                  F15
                            8DD1
                                     F16
                                               ADA2
                                                        F17
                                                                 84F1
F18
                                     F2
                                                        F20
                                                                 8358
         84F7
                  F19
                            836B
                                               0389
F21
         8505
                            8512
                                     F23
                                               AD26
                                                        F24
                                                                 9EBA
                  F22
                                                                 84BA
                            83DB
                                     F27
                                               84C0
                                                        F28
F25
         0419
                  F26
                                               84CE
                                                                 RCB<sub>6</sub>
F29
         8642
                  F3
                            0381
                                     F30
                                                        F31
F32
         801B
                  F33
                            871D
                                     F34
                                               87BF
                                                        F35
                                                                 OAC5
F36
         86BC
                  F4
                            OC34
                                     F5
                                               060A
                                                        F6
                                                                 0437
F7
         041F
                  FB.
                            844E
                                     EO
                                               8460
                                                        FBG
                                                                 3F20
FCHR2
         3780
                  FFCHK
                            0267
                                     FFEND
                                               3F9F
                                                        FFRD
                                                                 3FE5
FFSTRT
         3F50
                  FFWCT
                            3FEA
                                     FFWRT
                                               3FE6
                                                        FGNDF
                                                                 04F1
                  FRCR
                            0596
                                     FROW
                                               3FFE
                                                        FROWH
                                                                 3FFF
FIFACE
         004E
FS
         0437
                  FUNC
                            0168
                                     GECNTL
                                               3FEF
                                                        GRAPH
                                                                 A860
GSYMBL
         3FF3
                  HOMOUR
                            04DB
                                     ICMD
                                               3FE8
                                                        ILCHAR
                                                                 ОЗАВ
                            0547
                                     INIT
                                               00E2
                                                        INSCHA
                                                                 036B
ILELIN
         0202
                   ILNERG
INSCHR
         038D
                   INSLNE
                            0505
                                      INSLE
                                               039B
                                                        IRWOS
                                                                 05C1
                   ISNPA
                                      JMPADD
                                                                 0020
TSI RO
         0526
                            053C
                                               016A
                                                        KRD
                                     KBDLCK
                                                        KBDPRT
                                                                 0080
KBDACE
         01E4
                  KBDINT
                            0209
                                               3FEE
                                                        KULCDE
                                     KNACTV
KBLK
         04B6
                  KLCRTN
                            0260
                                               0327
                                                                 0003
LCL
         02F2
                  LCLFUN
                            005F
                                     LCLIND
                                               0002
                                                        LDFGD
                                                                 04FA
LEADIN
         3FE9
                   LENDLP
                            0729
                                     LF
                                               000A
                                                        LFD
                                                                 0301
                   LFSCR
LFEED
         03B1
                            O3D2
                                     LGPARA
                                               068D
                                                        LIN
                                                                 8000
                            02BE
                                     LINF
                                               3FA0
                                                        LINFH
                                                                 3FA1
LINC
         007E
                  LINEXE
                                     LINPFN
                                                                 02B3
LINMDE
         0283
                  LINP
                            3FA3
                                               02A4
                                                        LINPRA
```

LINSET LRDCUR LUBD NLC NPLP	02C5 0773 07F0 0800 05F9	LINWCT LROW MIDCHR NLCSE NPLT	3FA2 3FFC 0387 02EC 0601	LNSP LROWH MOVDWN NOWRAP NRW	0734 3FFD 054B 0066 3FF5	LOCLM LSTCHR MOVROW NPAGE ONLINE	3FF1 03C0 0550 05F3 0345
	EX MACRO	-ASSEMBL	ER V2.0		PAGE	31	
CRTB01 DUTACE	0079	OVRNG	032C	P32SYM	0700	P38SYM	06F3
P4SP	06FB	P6SYM	06F7	PATTN	0112	PGM	06D5
PGMLP	0702	PSPC	03A4	PTNLP	0117	PUSHSP	03EC
RDCUR	05D1	RDFIFO	026E	RDNEG	04A4	RDX	05E0
RDY	05E7	RFFRNG	027A	ROLDWN	048C	ROLUP	0472
ROM2	034F	ROSEOD	O5CD	ROSFFU	O5CB	ROW	8000
ROW1	0082	ROW10	0094	ROW11	0096	ROW12	0098
ROW13	009A	ROW14	009C	ROW15	009E	ROW16	00A0
ROW17	00A2	ROW18	00A4	ROW19	00A6	ROW2	00B4
RDW20	00AB	ROW21	OOAA	ROW22	OOAC	ROW23	OOAE
ROW24	00B0	ROW25	00B2	ROW26	00B4	ROW27	0086
ROW28	0088	ROW29	OOBA	ROW3	0065 0087	ROW30 ROW34	OOBC OOC4
ROW31 ROW35	OOBE	ROW32 ROW36	00C8	ROW33 ROW37	00C2	ROW34	0000
ROW39	OOCE	ROW4	0068	ROW40	OODO	ROW41	00D2
ROW42	00D4	ROW43	00D6	ROW44	00DB	ROW45	OODA
ROW46	OODC	ROW47	OODE	ROW47D	007E	ROW48	00E0
ROW48D	0080	ROW5	008A	ROW6	008C	ROW7	008E
ROWB	0090	ROW9	0092	ROWDP	0028	ROWPRT	0040
RR1	0182	RR10	0194	RR11	0196	RR12	0198
RR13	019A	RR14	019C	RR15	019E	RR16	01A0
RR17	01A2	RR18	01A4	RR19	01A6	RR1D	01E2
RR2	0184	RR20	01AB	RR21	O1AA	RR22	O1AC
RR23	01AE	RR24	01B0	RR25	01B2	RR26	0184
RR27	01B6	RR28	0188	RR29	O1BA	RR3	0186
RR30	OIBC	RR31	OIBE	RR32	01C0	RR33	0102
RR34	01C4	RR35	0106	RR36	0108	RR37	O1CA
RR38 RR41	0100	RR39 RR42	01CE 01D4	RR4 RR43	0188 01D6	RR40 RR44	01D0 01D8
RR45	01D2 01DA	RR46	O1DC	RR47	01DE	RR47D	017E
RR48	01E0	RR48D	0180	RR5	01BA	RR6	0180
RR7	018E	RRS	0190	RR9	0192	RTECTL	3FED
RTN	025F	RUADD	070C	RUNEQ	0484	RWRG	0060
SCALE	0784	SCATT	0667	SCLLP1	0799	SCLLP2	079D
SETSW	0040	SLNERG	0518	SNCNTL	073E	SNDCR	006B
SNDLNE	071D	SNDLP	0735	SPC	0020	START	0000
STFIFO	0244	STK	3FE5	STOFCH	0358	STOFLN	0512
STOFLP	035F	STSCN	06D0 ·	STSP	OACB	STUL	07D2
TAB	060A	TABSTP	0033	TBLJMP	0200	TDAOSP	0611
TGLCL	0333	TMCUR	062F	TOP	3FF6	TOPH	3FF7
TSANSP	0620	TSATT	0635	UCUR1	0451	ULCASE	3FF0
UPCUR	044E	VCAL	011F	VCALEN	3FF4	VERPRT	0040
VERT W1	0010	VERTDP W2	0030 2000	VRWRAP WAIT	0061 014E	VTSUB WFFRNG	07AE 025A
WI	1000 006D	WZ	2000	ZROCUR	014E 04DE	WEEKING	UZJA
HINCEA	2000	HINCED	JUDE	LNOCOK	JADE		

No Fatal error(s)

# Display Controllers/Drivers PRELIMINARY

# **DP-XXX Advanced Graphic CRT Controller, AGCRTC**

## **General Description**

The DP-XXX advanced graphic CRT controller, AGCRTC, provides a versatile, powerful and flicker-free solution to all raster scan graphic systems.

The AGCRTC performs six major tasks:

- 1) screen update
- 2) asynchronized pixel transfer
- 3) dynamic RAM refresh control
- 4) line drawing
- 5) text processing
- 6) scrolling

Multiple AGCRTCs can be used in the same system for color graphics or for faster system throughput.

#### **Features**

- Supports maximum 2048 pixels by 2048 lines raster scan display
- 16 or 32-bit wide data bus and 20-bit wide address bus
- Maximum frame buffer size up to 16 megapixels
- Screen parameters are programmable, including sync, blanking, screen size, etc.
- System parameters are programmable, including refresh, data bus width

- Supports both interlaced and noninterlaced raster scan displays.
- Supports BITBLT with clipping window
- Fast scrolling—a 1k by 1k display area can be scrolled in any direction within one frame time at 70 Hz, noninterlaced
- Line drawing at 200 ns per pixel
- Supports proportional spacing for word processing
- Horizontal and vertical SYNC inputs allow the AGCRTC to lock to other video sources
- AGCRTC generates either composite SYNC or separate vertical and horizontal SYNCs
- Dynamic RAM refresh support
- Supports color graphics
- Easy interfacing to all popular microprocessors
- Versatile handshake signals for maximum utilization of the available bus bandwidth
- Pipelined data input and output structures for high system throughputs
- Maximum transfer rate, 320 megapixels per second
- High-speed CMOS technology
- 68-pin leaded chip carrier

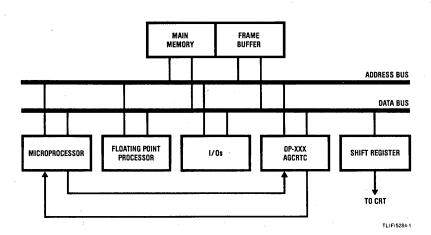


FIGURE 1. Single Bus System Diagram

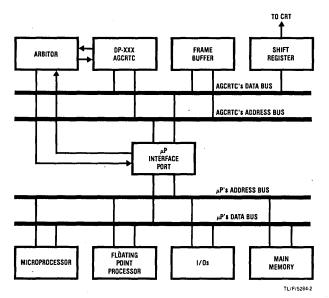


FIGURE 2. Dual Bus System Diagram

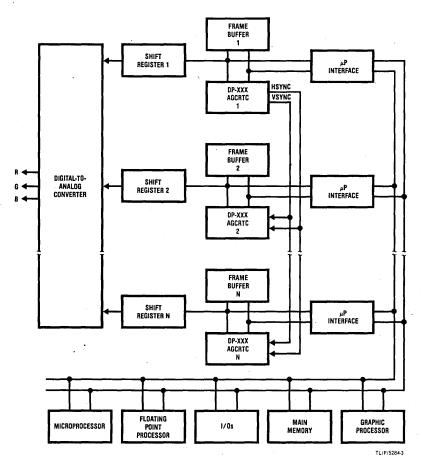


FIGURE 3. Multiple Bitplanes, Multiple AGCRTCs System



# **Display Controllers/Drivers**

# DS75491 MOS-to-LED Quad Segment Driver DS75492 MOS-to-LED Hex Digit Driver

## **General Description**

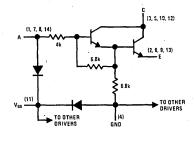
The DS75491 and DS75492 are interface circuits designed to be used in conjunction with MOS integrated circuits and common-cathode LED's in serially addressed multi-digit displays. The number of drivers required for this time-multiplexed system is minimized as a result of the segment-address-and-digit-scan method of LED drive.

#### **Features**

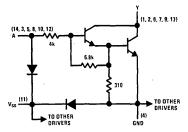
- 50 mA source or sink capability per driver (DS75491)
- 250 mA sink capability per driver (DS75492)
- MOS compatability (low input current)
- Low standby power
- High-gain Darlington circuits

## **Schematic and Connection Diagrams**

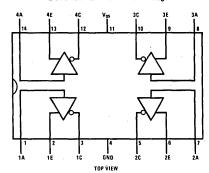
DS75491 (each driver)



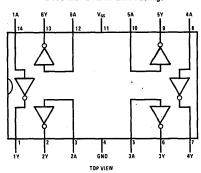
DS75492 (each driver)



#### DS75491 Dual-In-Line Package



DS75492 Dual-In-Line Package



Order Number DS75491J, DS75492J, DS75491N or DS75492N See NS Package J14A or N14A

Abso	lute	Maxin	num	Ratings	(Note 1)
MUJU	ıuıc	ITIGALI	II WILL	Haumas	i unote il

9	DS75491	DS75492
Input Voltage Range (Note 4)	−5V to V <sub>SS</sub>	-5V to V <sub>SS</sub>
Collector Output Voltage (Note 5)	10V	10V
Collector Output to Input Voltage	10V	10V
Emitter to Ground Voltage $(V_1 \ge 5V)$	10V	
Emitter to Input Voltage	5V	
Voltage at V <sub>SS</sub> Terminal With Respect to Any Other Device Terminal	10V	10V
Collector Output Current		
Each Collector Output	50 mA	250 mA
All Collector Outputs	200 mA	600 mA
Continuous Total Dissipation	600 mW	600 mW
Operating Temperature Range	0°C to +70°C	0°C to +70°C
Storage Temperature Range	-65°C to +150°C	-65°C to +150°C
Lead Temperature (Soldering, 10 sec)	300°C	300°C
Maximum Power Dissipation at 25°C		
Cavity Package	1308 mW *	1364 mW <sup>†</sup>
Molded Package	1207 mW *	1280 mW <sup>†</sup>

<sup>\*</sup>Derate cavity package 8.72 mW/°C above 25°C; derate molded package 9.66 mW/°C above 25°C.

## Electrical Characteristics DS75491 (V<sub>SS</sub> = 10V, T<sub>A</sub> = 0°C to +70°C unless otherwise noted) (Notes 2 and 3)

	PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS
V <sub>CE ON</sub>	"ON" State Collector Emitter Voltage	Input = 8.5V V <sub>E</sub> = 5V, I <sub>C</sub>	through 1 k $\Omega$ , = 50 mA	$T_A = 25^{\circ}C$ $T_A = 0-70^{\circ}C$		0.9	1.2	. V
I <sub>C OFF</sub>	"OFF" State Collector Current	V <sub>C</sub> = 10V, V <sub>E</sub> = 0V	$I_{1N} = 40\mu A$ $V_{1N} = 0.7V$				100 100	·μΑ μΑ
11	Input Current at Maximum Input Voltage	V <sub>IN</sub> = 10V, V	/ <sub>E</sub> = 0, I <sub>C</sub> = 20 m	nA		2.2	3.3	mA
I <sub>E</sub>	Emitter Reverse Current	V <sub>IN</sub> = 0, V <sub>E</sub>	= 5V, I <sub>C</sub> = 0				100	μΑ
I <sub>ss</sub>	Current Into V <sub>SS</sub> Terminal						1	mA

#### **DS75492** $\{V_{SS} = 10V, T_A = 0^{\circ}C \text{ to } +70^{\circ}C \text{ unless otherwise noted}\}$ (Notes 2 and 3)

	PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS
V <sub>OL</sub>	Low Level Output Voltage	Input = 6.5V t I <sub>OUT</sub> = 250 m		$T_A = 25^{\circ}C$ $T_A = 0-70^{\circ}C$		0.9	1.2 1.5	V
ГОН	High Level Output Current	V <sub>OH</sub> = 10V	$I_{1N} = 40\mu A$ $V_{1N} = 0.5V$				200	μA μA
l <sub>i</sub>	Input Current at Maximum Input Voltage	V <sub>IN</sub> = 10V, I <sub>C</sub>	<sub>L</sub> = 20 mA			2.2	3.3	mA
Iss	Current Into V <sub>SS</sub> Terminal						1	mA

## Switching Characteristics DS75491 (V<sub>SS</sub> = 7.5V, T<sub>A</sub> = 25°C)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High Level Output (Collector)	V <sub>IH</sub> = 4.5V, V <sub>E</sub> = 0,		100		ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low Level Output (Collector)	$R_{L} = 200\Omega, C_{L} = 15 pF$		20		ns

## **DS75492** ( $V_{SS} = 7.5V, T_A = 25^{\circ}C$ )

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High Level Output	$V_{IH} = 7.5V, R_{L} = 39\Omega,$		300		ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low Level Output	C <sub>L</sub> = 15 pF		30		ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C temperature range for the DS75491 and DS75492.

Note 3:All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: The input is the only device terminal which may be negative with respect to ground.

Note 5: Voltage values are with respect to network ground terminal unless otherwise noted.

<sup>&</sup>lt;sup>†</sup>Derate cavity package 9.09 mW/° C above 25° C; derate molded package 10.24 mW/° C above 25° C.

# **AC Test Circuits and Switching Time Waveforms**

DS75491

PULSE CENERATOR (NOTE 1)

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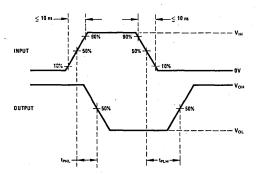
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DS75492



Note 1: The pulse generator has the following characteristics: Z $_{OUT}$  = 50  $\!\Omega$  , PRR = 100 kHz, t $_{\rm W}$  = 1 $\mu s$ 



# **Display Controllers/Drivers**

# DS55493/DS75493 Quad LED Segment Driver

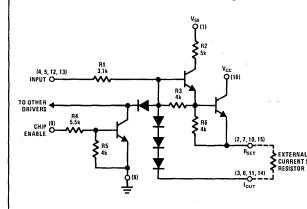
## **General Description**

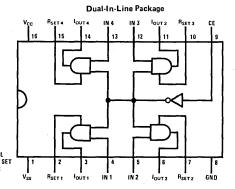
The DS55493/DS75493 is a quad LED segment driver. It is designed to interface between MOS IC's and LED's. An external resistor is required for each segment to drive the output current which is approximately equal to  $0.7V/R_L$  and is relatively constant, independent of supply variations. Blanking can be achieved by taking the chip enable (CE) to a logical "1" level.

#### **Features**

- Low voltage operation
- Low input current for MOS compatibility ·
- Low standby power
- Display blanking capability
- Output current regulation
- Quad high gain circuits

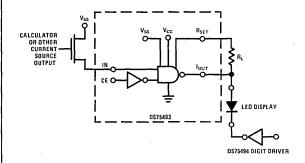
## **Schematic and Connection Diagrams**





Order Number DS55493J, DS75493J or DS75493N See NS Package J16A or N16A

## **Typical Application**



## **Truth Table**

CE	V <sub>IN</sub>	l <sub>out</sub>
0	1	ON
0	0	OFF
1	х	OFF

X = Don't care

Cavity Package

Molded Package

Lead Temperature (Soldering, 10 seconds)

## **Absolute Maximum Ratings** (Note 1)

 Supply Voltage
 10V

 Input Voltage
 10V

 Output Voltage
 VCC

 Storage Temperature Range
 -65° C to +150° C

 Output Current (IOUT)
 -25 mA

 Maximum Power Dissipation\* at 25° C

 VCC
 VSS

 o +150°C
 Temperature, TA

 -25 mA
 DS75493

 1371 mW
 DS55493

Supply Voltage

Vcc

**Operating Conditions** 

UNITS

٧

°C

°C

°C

MAX

8.8

8.8

+70

+125

32

0

--55

## **Electrical Characteristics** ( $V_{ss} \ge V_{cc}$ ) (Notes 2 and 3)

PARAMETER		CONDIT	MIN	TYP	MAX	UNITS	
I <sub>IN</sub>	Input Current	$V_{SS} = Max$ , $V_{IN} = 8.8V$ , $V_{CC} = Open$ , $V_{CE} = 0V$ $I_{OUT} = R_{SET} @ 0V$ , $V_{CE} = 8.8V$				3.2 3.6	mA mA
I <sub>CE</sub>	Chip Enable Input Current	$V_{CC} = Max$ , $V_{SS} = Max$ , $V_{CE} = 8.8V$ , All Other Pins to Gnd				2.1	mA
1 <sub>OUT</sub>	Output Current	I <sub>OUT</sub> @ 2.15V, R <sub>L</sub> = 50Ω	$V_{CC}$ = Min, $V_{SS}$ = 6.5V, $I_{CE}$ = 80 $\mu$ A, $V_{IN}$ = 6.5V Through 1.0 k $\Omega$	-8	-13		mA
			$V_{CE} = 0V, V_{IN} = 8.8V$		-16	-20	mA
I <sub>OL</sub> O	Output Leakage Current	I <sub>OUT</sub> = R <sub>SET</sub> @ 0V,	$V_{CC}$ = Min, $V_{CE}$ = 0V $V_{IN}$ = 8.8V Through 100 k $\Omega$			-100	μΑ
		Measure Current to Gnd, V <sub>SS</sub> = 8.8V	V <sub>CE</sub> = 6.5V Through 1.0 kΩ, V <sub>IN</sub> = 8.8V			-200	μΑ
Icc	Supply Current, V <sub>CC</sub>	V <sub>CC</sub> = Max, V <sub>SS</sub> = Max, A			40	μΑ	
I <sub>SS</sub>	Supply Current	V <sub>CC</sub> = 0V, All Other Pins t	V <sub>CC</sub> = 0V, All Other Pins to Gnd			40	μΑ
		V <sub>CC</sub> = Min, V <sub>SS</sub> = 8.8V	$I_{OUT}$ @ 2.15V, $V_{CE}$ = 8.8V Through 100 k $\Omega$ , $R_L$ = 50 $\Omega$		0.5	1.5	mA
			I <sub>OUT</sub> = Open, R <sub>SET</sub> = Open, V <sub>CE</sub> = 0V			1.4	mA

## Switching Characteristics T<sub>A</sub> = 25°C, nominal power supplies unless otherwise noted

1280 mW

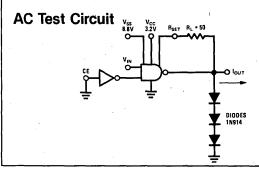
300°C

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd</sub> (OFF)	Propagation Delay to a Logical "0" From Input to Output	(See AC Test Circuit)		170	300	ns
t <sub>pd</sub> (ON)	Propagation Delay to a Logical "1" From Input to Output	(See AC Test Circuit)		11	100	ns

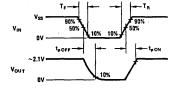
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range for the DS75493 and across the -55°C to +125°C range for the DS55493.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.



## **Switching Time Waveforms**



<sup>\*</sup>Derate cavity package 9.14 mW/° C above 25° C; derate molded package 10.24 mW/° C above 25° C.



# **Display Controllers/Drivers**

# DS55494/DS75494 Hex Digit Driver

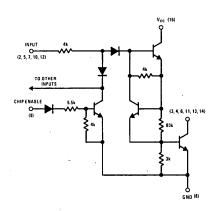
## **General Description**

The DS55494/DS75494 is a hex digit driver designed to interface between most MOS devices and common cathodes configured LED's with a low output voltage at high operating currents. The enable input disables all the outputs when taken high.

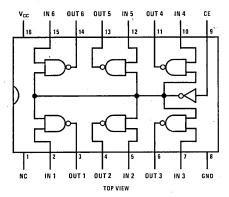
### **Features**

- 150 mA sink capability
- Low voltage operation
- Low input current for MOS compatibility
- Low standby power
- Display blanking capability
- Low voltage saturating outputs
- Hex high gain circuits

## **Schematic and Connection Diagrams**



#### Dual-In-Line Package



Order Number DS55494J, DS75494J or DS75494N See NS Package J16A or N16A

#### **Truth Table**

ENABLE	V <sub>IN</sub>	V <sub>OUT</sub>
0	0	1
0	1	0
1	x	1

X = don't care

## Absolute Maximum Ratings (Note 1)

## **Operating Conditions**

			MIN	MAX	UNITS
Supply Voltage	10V ·	Supply Voltage, V <sub>CC</sub>	3.2	8.8	V
Input Voltage Output Voltage Storage Temperature Range Maximum Power Dissipation* at 25°C	10V 10V –65°C to +150°C	Temperature, T <sub>A</sub> DS75494 DS55494	0 -55	+70 +125	°C °C
Cavity Package	1433 mW	•			
Molded Package	1362 mW				

300° C

Lead Temperature (Soldering, 10 seconds)

## Electrical Characteristics (Notes 2 and 3)

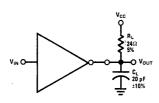
PARAMETER		CONDITIONS			MIN	TYP	MAX	UNITS		
I <sub>IH</sub> Logical "1" Input Current		V <sub>CE</sub> = 8.8V through		through 100k				2.0	mA	
		V <sub>CC</sub> = Min, V <sub>IN</sub> = 8.8V		V <sub>CE</sub> = 8.8V				2.7	mA	
IIL	Logical "0" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = -5.5V						-20	μΑ	
IOH Logical "1" Output Current				V <sub>IN</sub> = 8.8V through 100k, V <sub>CE</sub> = 0V				. 400	μΑ	
		$V_{CC} = Max, V_{OH} = 8.8V$		V <sub>IN</sub> = 8.8V, V <sub>CE</sub> = 6.5V through 1.0k				400	μΑ	
V <sub>OL</sub>	Logical "0" Output Voltage	V <sub>CC</sub> = Min, I <sub>C</sub>	V <sub>CC</sub> = Min, I <sub>OL</sub> = 150 mA, V <sub>IN</sub> = 6.5V through 1.0k, DS75494					0.25	0.35	V
	, r	V <sub>CE</sub> = 8.8V ti	.8V through 100k DS55494		DS55494		0.25	0.4	V	
Icc	Supply Current	V <sub>CC</sub> = Max	One Driver "ON", V., = 8.8V		DS75494			8.0	mA	
					DS55494			10.0	mA	
			All Other Pins to GNE		V <sub>CE</sub> = 6.5V	V <sub>CE</sub> = 6.5V through 1.0k			100	μΑ
			All Other F	ins to GND	V <sub>IN</sub> = 8.8V through 100k				100	μΑ
		•	All Other F	All Other Pins to GND				40	μΑ	
toff	Output "OFF" Time	$C_L = 20 \text{ pF}$ , $R_L = 24\Omega$ , $V_{CC} = 4.0V$ , See ac Test Circuits					0.04	1.2	μς	
ton	Output "ON" Time	$C_L = 20 \text{ pF}, R_L = 24\Omega, V_{CC} = 4.0V, \text{See ac Test Circuits}$				s		13	100	ns

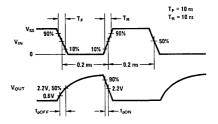
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range for the DS75494 and across the -55°C to +125°C range for the DS55494.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absulute value basis.

## **AC Test Circuit and Switching Time Waveforms**





<sup>\*</sup>Derate cavity package 9.55 mW/° C above 25° C; derate molded package 10.9 mW/° C above 25° C.

#### DS8654 8-Output Display Driver (LED, VF, Thermal Printer) **DS8656 Diode Matrix**

#### **General Description**

DS8654 is an 8-digit driver with emitter/follower outputs. It can source up to 50 mA at a low impedance, and operates with a constant internal drive current over a wide range of power supply-from 4.5V to 33V. The DS8654 can be used to drive electrical or mechanical, multiplexed or unmultiplexed display systems. It can be used as a segment driver for common cathode displays with external current limiting resistors or can drive incandescent or fluorescent displays directly, both digits (anodes) and segments (grids). It will be necessary to run the device at a lower duty cycle, to keep the maximum package dc power dissipation less than 600 mW while operating all 8 outputs at high supply voltage and large source current. The inputs are MOS compatible and eliminate the need for level shifting since inputs are referenced to the most negative supply of system.

#### System Description

The DS8654 and DS8656 are specifically designed to operate a thermal printing head for calculator or other

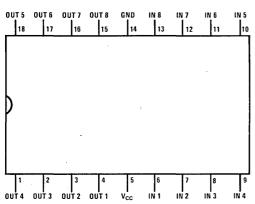
Dual-In-Line Package

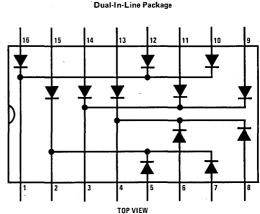
uses. In this application the same segment in each digit is selected at the same time, reducing the overall time for a complete print cycle. The DS8654 is an 8-digit driver. With a 15-digit print head, two of the DS8654 are required.

The DS8656 diode arrays are used to prevent "sneak" currents in the resistive print head. In a 15-digit print head with one alphanumeric digit there are 119 resistor segments requiring 119 diodes. For ease of assembly, the DS8656 is configured in four groups of three common cathode diodes in each group. In the system, ten parts of DS8656 are required.

The whole system is designed to operate from a +19V supply for the print head and an 8-cell nickel-cadmium battery supplying -8V to -11.6V for the rest of the electronics. The 8-segment drive transistors require  $LV_{CER}$ 's of 33V min,  $\beta$  of > 100 at  $I_C$  = 500 mA, and  $V_{SAT} < 1.0V$  at 800 mA with 15 mA drive.

#### **Connection Diagrams**





Order Number DS8654N See NS Package N18A

Order Number DS8656N See NS Package N16A

#### Absolute Maximum Ratings DS8654 (Note 1) Operating Conditions DS8654 UNITS Supply Voltage (VCC) 33 Supply Voltage 4.5 Input Voltage 36V °C Temperature (TA) +70 V<sub>CC</sub> – 36V Output Voltage -65°C to +150°C Storage Temperature Range Maximum Power Dissipation at 25°C Molded Package (DS8654)\* 1563 mW Molded Package (DS8656)† 1280 mW Lead Temperature (Soldering, 10 seconds) 300° C

#### Electrical Characteristics DS8654 (Notes 2 and 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
l <sub>iH</sub>	Logical "1" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 6.5V		390	500	μΑ
I <sub>IL</sub>	Logical "0" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V		13	40	μΑ
lorif	"Off" State Leakage Current	V <sub>OUT</sub> = V <sub>CC</sub> - 33V		0.01	-100	μΑ
V <sub>oN</sub>	"On" State Output Voltage	$V_{CC} = Max$ , $I_{IN} = 500\mu A$ , $I_{OH} = -50 \text{ mA}$		V <sub>cc</sub> -1.8	V <sub>CC</sub> -2.5	V
I <sub>CC(OFF)</sub>	Supply Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = V <sub>OUT</sub> = Gnd		0.01	1.0	mA
I <sub>CC(ON)</sub>	Supply Current (All Outputs "ON")	$V_{CC} = Max$ , $V_{IN} = 6.5V$ , $I_{OUT} = 0 \text{ mA}$		7.5	10	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

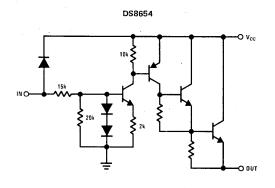
Note 2: Unless otherwise specified min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8654. All typicals are given for  $V_{CC} = 30V$  and  $T_A = 25^{\circ}$ C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

#### Electrical Characteristics DS8656 (T<sub>A</sub> = 0°C to +70°C)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
Va	Peak Inverse Voltage	I <sub>R</sub> = 0.1 mA	35			V
V <sub>F</sub>	Forward Voltage	I <sub>F</sub> = 50 mA .			1.5	V
tr	Reverse Recov. Time	$I_F = 50 \text{ mA to } I_R = 0.1 \text{ mA at } V_R = 30 \text{ V}$			1.0	μs

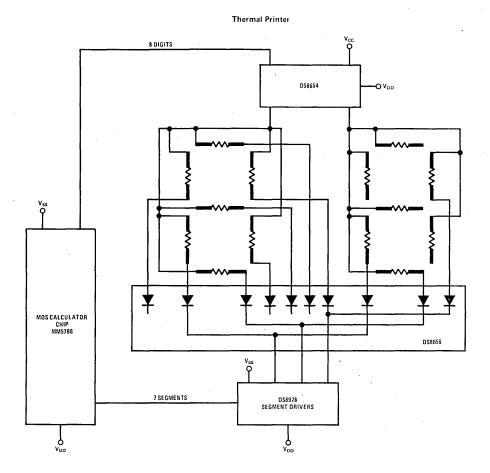
#### **Schematic Diagram**



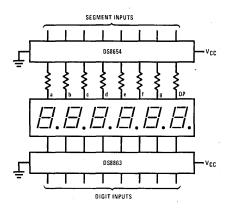
<sup>\*</sup>Derate molded package 12.5 mW/°C above 25°C.

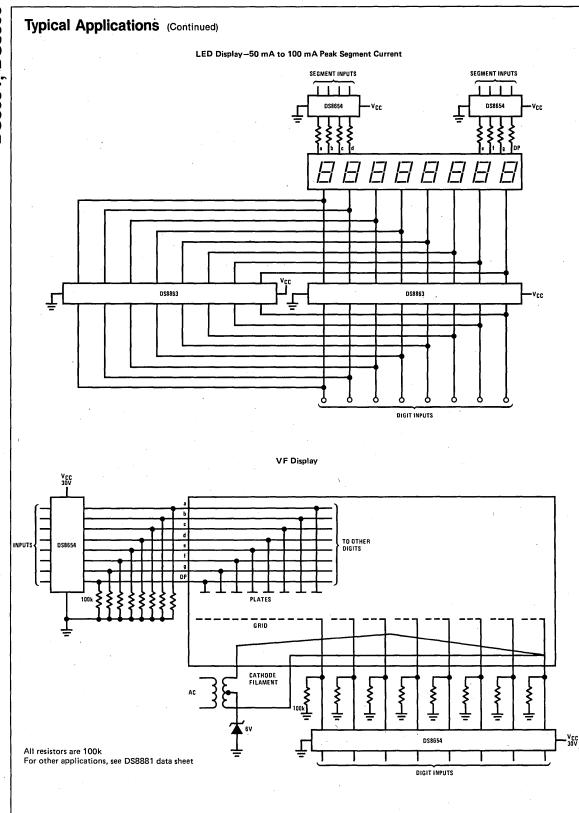
<sup>&</sup>lt;sup>†</sup>Derate molded package 10.24 mW/° C above 25° C.

# **Typical Applications**



#### LED Display-0 mA to 50 mA Peak Segment Current





# DS8664 14-Digit Decoder/Driver With Low Battery Indicator

#### **General Description**

The DS8664 circuit is a 14-digit decoder/driver with an 80 mA sink capability. The circuit has current threshold inputs, and is designed to be driven by P-channel MOS. The enable input permits interdigit blanking of the decoded outputs. An open-collector output oscillator is provided for system timing (two passive external components are required). A low-battery indicator is provided at the "C" input with a nominal trip point of 3.25V at 25°C.

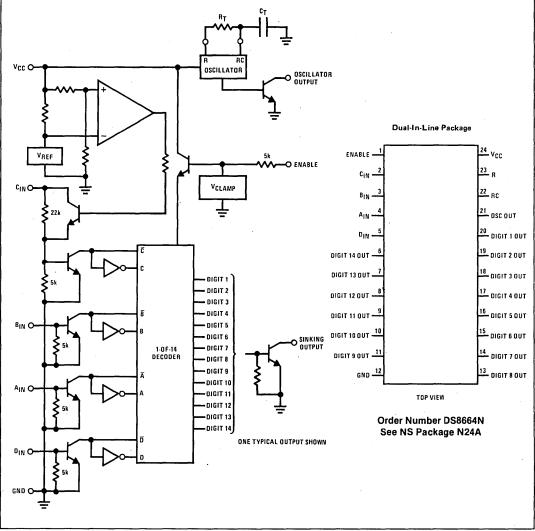
#### **Features**

Oscillator frequency accuracy allows maximum system speed

**Display Controllers/Drivers** 

- Inter-digit blanking with the enable input provides ghost-free display operation
- Low-battery indicator accuracy provides consistent low-battery indication

#### **Logic and Connection Diagrams**



#### Absolute Maximum Ratings (Note 1)

10V ±10V ±1.5 mA 10V

10V –65°C to +150°C

Maximum Power Dissipation\* at 25°C

Supply Voltage Input Voltage

Input Current

Output Voltage Storage Temperature Range

Molded Package Lead Temperature (Soldering, 10 seconds) 2005 mW 300° C

# **Operating Conditions**

Supply Voltage (V <sub>CC</sub> )	MIN 2.9	MAX 9.5	UNITS V
Temperature (T <sub>A</sub> )	0	+70	°c

#### Electrical Characteristics (Notes 2 and 3)

PARAMETER		CONDITIONS			TYP	MAX	UNITS
VIH	Logical "1" Input Voltage Decoder Inputs	VCC = Max, VENABLE = 4.9V	I <sub>IN</sub> = 260μΑ I <sub>IN</sub> = 1400μΑ	0.50		1.50	- V
VIH	Enable Input	VCC = Max, IENABLE = 260μA,	T <sub>A</sub> = 25°C	3.0	4.2	5.1	v
ЧН	Logical "1" Input Current Decoder Inputs	VCC = Max, VENABLE = 4.9V		260			μΑ
Iн	Enable Inpút	VCC = Max		260			μΑ
VIL	Logical "0" Input Voltage	V <sub>CC</sub> = Max, V <sub>ENABLE</sub> = 4.9V, I <sub>IL</sub> = 25μA	AIN,BIN,DIN CIN			0.30 0.50	V
lir.	Logical "O" Input Current	VCC = Max, VENABLE = 4.9V, V	IL = Max			25	μΑ
Vон	C Input (Low-Battery Output)	V <sub>CC</sub> = 3.1V, T <sub>A</sub> = 25°C	I <sub>IN</sub> = 300μA I <sub>IN</sub> = 400μA	4.9 6.5	7.3 10.0		V
VoL	C Input (Low-Battery Output)	V <sub>CC</sub> = 3.4V, I <sub>IN</sub> = 1300μA, T <sub>A</sub> = 25°C			1.0	3.0	V
ЮН	Logical "1" Output Current Except Pin R	V <sub>CC</sub> = Max, V <sub>OH</sub> = 10.0V, V <sub>ENABLE</sub> = 4.9V V <sub>BC</sub> = 0.6V				50	μΑ
los	Output Short Circuit Current Pin R Only	V <sub>CC</sub> = Max, V <sub>RC</sub> = 0.6V		-0.15	-0.28	-0.45	mA
VOL	Logical "O" Output Voltage Digit Outputs	VCC = Min, IOL = 80 mA, VENA	BLE = 4.9V		0.35	0.55	٧
Vol(osc)	Oscillator Output	VCC = Min, IOL = 6 mA, VRC = 1	1.5V		0.20	0.55	V
V <sub>OL</sub>	Pin R	V <sub>CC</sub> = Min, I <sub>OL</sub> = 60μA, V <sub>RC</sub> = 1	1.5V		0.10	0.25	v
Icc	Supply Current-Enabled	VCC = Max, VENABLE = 4.9V			15.0	22.0	m.A
Icc	Supply Current-Disabled	VCC = Max, VENABLE = 1.0V			6.0	12.0	m A
fosc	Oscillator Frequency	$R_T = 35k \pm 2\%$ , $C_T = 100 pF \pm 5\%$ , $R_T = 33k \pm 2\%$ , $C_T = 100 pF \pm 5\%$		300 320	350 360	400 400	kHz kHz
D.C.	Duty Cycle (tpwH/τ)	R <sub>T</sub> = 35k ±2%, C <sub>T</sub> = 100 pF ±5%		0.46	0.56	0.66	

#### Switching Characteristics $V_{CC} = 4.0V$ , $T_A = 25^{\circ}C$ unless otherwise specified.

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd1</sub> or t <sub>pd0</sub>	Propagation Delay From A, B, C, D Inputs to Digit Outputs	$R_{IN} = 8.2k$ , $V_{ENABLE} = 10V$ , $R_{L} = 100\Omega$ , $C_{L} = 50 pF$			500	ns
<sup>t</sup> pd0	Propagation Delay to a Logical "0" From Enable Input to Digit Outputs	$R_{IN} = 8.2k, R_{L} = 100\Omega, C_{L} = 50 pF$	30	80	200	ns
<sup>t</sup> pd1	Propagation Delay to a Logical "1" From Enable Input to Digit Outputs	$R_{1N} = 8.2k$ , $R_{L} = 100\Omega$ , $C_{L} = 50 pF$	100	250	500	ns

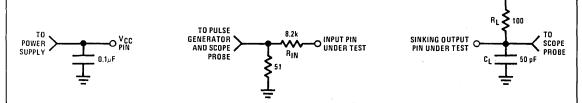
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the  $0^{\circ}$ C to +70 $^{\circ}$ C range; all typical values are given for V<sub>CC</sub> = 4.0V and T<sub>A</sub> = 25 $^{\circ}$ C.

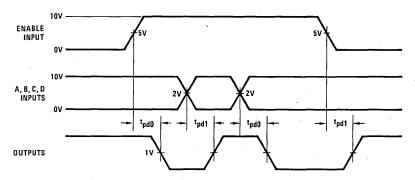
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

<sup>\*</sup>Derate molded package 16.04 mW/° C above 25° C.

# **AC Test Circuits and Switching Time Waveforms**







Note: Input voltage rise and fall times are 120 ns from 10% to 90% points.

#### **Truth Table**

A <sub>IN</sub>	B <sub>IN</sub>	CIN	D <sub>IN</sub>	DIG. OUT ON
0,	0	0	0	NONE
1	0	0	0	1
0	1	0	0	2
1	1	0	0	. 3
0	0	1	0	4
] 1 ]	0	1	0	5
0	1	1	0	6
1	-1	1	0	7
0	0	0	1	8
1	0	0	1	9
0	1	0	1	10
1	1	0	1	11 .
0	0	1	[ 1 ]	12
1	0	1	1	13
0	1	1	1	· 14
1	1	1	1	NONE



# DS8666 14-Digit Decoder/Driver

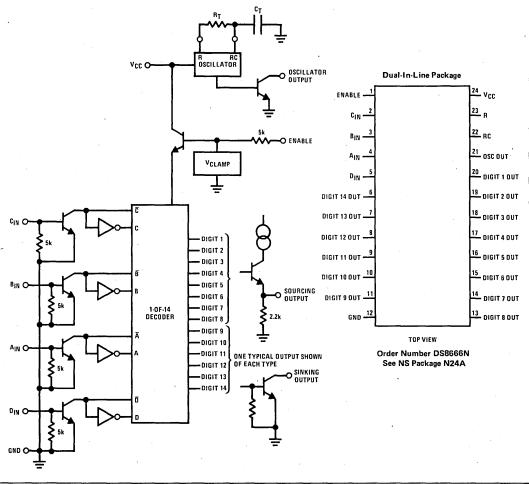
#### **General Description**

The DS8666 circuit is a 14-digit decoder/driver. Six outputs have an 80 mA sink capability, and eight of the outputs have a 13 mA nominal source drive capability to drive external grounded-emitter transistor bases. The circuit has current threshold inputs, and is designed to be driven by P-channel MOS. An enable input is provided to allow for inter-digit blanking of the decoded outputs. An open-collector output oscillator is provided for system timing (two passive external components are required).

#### **Features**

- Oscillator frequency accuracy allows maximum system speed
- Inter-digit blanking with the enable input provides ghost-free display operation

#### **Logic and Connection Diagrams**



MAX

9.5 +70

7.9

#### Absolute Maximum Ratings (Note 1)

#### **Operating Conditions**

Supply Voltage (V<sub>CC</sub>)

Temperature (TA)

Supply Voltage	10V
Input Voltage	10V
Input Current	±1.5 mA
Output Voltage	10V
Storage Temperature Range	-65°C to +150°C
Maximum Power Dissipation* at 25°C	
Molded Package	2005 mW
Lead Temperature (Soldering, 10 seconds)	300° C
*Derata malded package 16.04 mW/°C above	25° C

Derate molded package 16.04 mW/°C above 25°C.

#### Floringal Characteristics (Notes 2 and 2)

	PARAMETER	CONDITIONS			TYP	MAX	UNITS
VIH	Logical "1" Input Voltage Decoder Inputs	V <sub>CC</sub> = Max, V <sub>ENABLE</sub> = 6.7V	I <sub>IN</sub> = 390 μA I <sub>IN</sub> = 1400 μA	0.50		1.50	V
VIH	Enable Input	VCC = Max, IENABLE = 140 μA		5.0	6.3	7.0	٧
ЧН	Logical "1" Input Current Decoder Inputs	V <sub>CC</sub> = Max, V <sub>ENABLE</sub> = 6.7V	•	390			μА
I <sub>IH</sub>	Enable Input	V <sub>CC</sub> = Max		140			μΑ
VIL	Logical "0" Input Voltage	V <sub>CC</sub> = Max, V <sub>ENABLE</sub> = 6.7V,	IL = 25 μA			0.30	<b>&gt;</b>
I <sub>IL</sub>	Logical "0" Input Current	VCC = Max, VENABLE = 6.7V, V	/IL = Max			25	μΑ
IOH(OSC)	Oscillator Output	V <sub>CC</sub> = Max, V <sub>OH</sub> = 10.0V, V <sub>RC</sub>	= 0.6V			50	μΑ
ЮН	Digit 1-8 Outputs	V <sub>CC</sub> = Max, V <sub>OH</sub> = 1.00V, V <sub>ENABLE</sub> = 6.7V		-7.0	-13.0	-20.0	mA
Іон	Logical "1" Output Current Digit 9-14 Outputs	V <sub>CC</sub> = Max, V <sub>OH</sub> = 10.0V, V <sub>ENABLE</sub> = 6.7V				50	μА
los	Output Short-Circuit Current Pin R Only	V <sub>CC</sub> = Max, V <sub>RC</sub> = 0.6V		-0.15	-0.30	-0.45	mA
Vol(osc)	Oscillator Output	VCC = Min, IOL = 6 mA, VRC =	1.5V			0.50	٧
VoL	Logical "0" Output Voltage Digit 1-8 Outputs Digit 9-14 Outputs Pin R	VCC = Min, VENABLE = 6.7V	I <sub>OL</sub> = 40 μA I <sub>OL</sub> = 80 mA I <sub>OL</sub> = 60 μA, VRC = 1.5V		0.35 0.10	0.40 0.50 0.20	V V V
<sup>1</sup> cc	Supply Current—Enabled	V <sub>CC</sub> = Max, V <sub>ENABLE</sub> = 6.7V, V <sub>OH</sub> = 1.00V, (Sourcing Output "ON")			26.0	35.0	mA
Icc	Supply Current—Disabled	V <sub>CC</sub> = Max, V <sub>ENABLE</sub> = 1.0V			5.0	7.0	mA
fosc	Oscillator Frequency	R <sub>T</sub> = 33k ±2%, C <sub>T</sub> = 100 pF ±5%	V <sub>CC</sub> = Min V <sub>CC</sub> = Max	320	360	400	kHz
D.C.	Duty Cycle (tp <sub>WH</sub> /τ)	R <sub>T</sub> = 33k ±2%, C <sub>T</sub> = 100 pF ±5%	V <sub>CC</sub> = Min V <sub>CC</sub> = Max	0.46	0.56	0.66	

# Switching Characteristics V<sub>CC</sub> = 8.4V, T<sub>A</sub> = 25°C

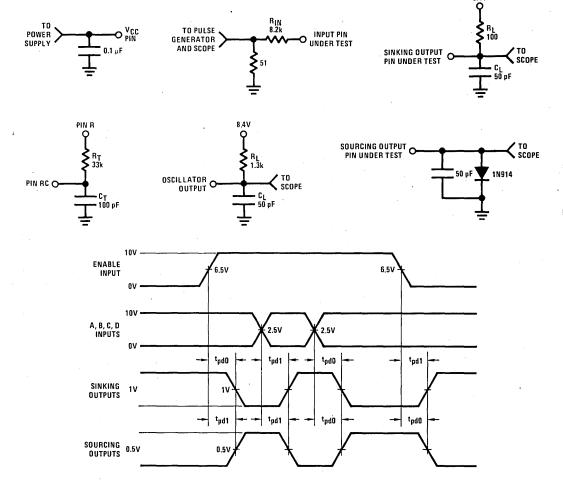
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd0</sub> or t <sub>pd1</sub>	Propagation Delay From A, B, C, D Inputs to Digit Outputs	R <sub>IN</sub> = 8.2k, V <sub>ENABLE</sub> = 10V, C <sub>L</sub> = 50 pF			500	ns
t <sub>pd0</sub> or tpd1	Propagation Delay From Enable Input to Digit Outputs	R <sub>IN</sub> = 8.2k, C <sub>L</sub> = 50 pF			500	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C for the DS8666. All typicals are given for V<sub>CC</sub> = 8.4V and  $T_A = 25^{\circ} C$ .

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

# **AC Test Circuits and Switching Time Waveforms**



Note. Input rise and fall times are 120 ns between 10% and 90% points.

#### **Truth Table**

AIN	BIN	CIN	DIN	DIG. OUT ON
0	0	0	0	NONE
1 1	0	0	0	1
0	1	0	0	2
1	1	0	0	3
0	0	1	0	4
1	0	1	0	5
0	1	1	0	6
1	1	1	0	7
0	0	0	1	8
1	0	0	1	9
0	1	0	1	10
1	1	0	1	11
0	0	1	1	12
1	0	1	1	13
0	1	1	1	14
1	1	1	1	NONE

# DS8669 2-Digit BCD to 7-Segment Decoder/Driver

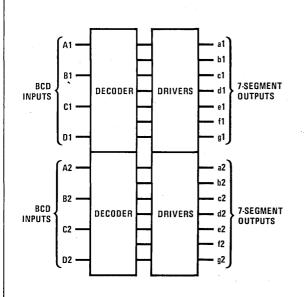
#### **General Description**

The DS8669 is a 2-digit BCD to 7-segment decoder/driver for use with common anode LED displays. The DS8669 drives 2 7-segment LED displays without multiplexing. Outputs are open-collector, and capable of sinking 25 mA/segment. Applications include TV and CB channel displays.

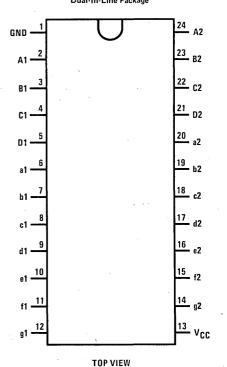
#### **Features**

- Direct 7-segment drive
- 25 mA/segment current sink capability
- Low power requirement—16 mA typ
- Very low input currents-2 μA typ
- Input clamp diodes to both VCC and ground
- No multiplexing oscillator noise

#### **Logic and Connection Diagrams**



#### Dual-In-Line Package



Order Number DS8669N See NS Package N24A

#### Absolute Maximum Ratings (Note 1)

#### **Operating Conditions**

Supply Voltage	<b>7</b> V
Input Current	20 mA
Output Voltage	12V
Storage Temperature Range	-65°C to +150°C
Maximum Power Dissipation* at 25°C	
Molded Package	2005 mW
Lead Temperature (Soldering, 10 seconds)	300°C

#### Electrical Characteristics V<sub>CC</sub> = 5.25V, (Note 2)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
VIH	Logical "1" Input Voltage	V <sub>CC</sub> = Min	2.0		V <sub>CC</sub> +0.6	V
۷IL	Logical "0 ' Input Voltage	V <sub>CC</sub> = Min	-0.3		0.8	, V
Io	Logical "1" Output Leakage Current	V <sub>CC</sub> = Max, V <sub>OUT</sub> = 10V			50	μΑ
VOL	Logical "0" Output Voltage	I <sub>OL</sub> = 25 mA, V <sub>CC</sub> = Min		0.4	0.8	V
JIH .	Logical "1" Input Current	V <sub>IN</sub> = V <sub>CC</sub> = Max		2.0	10	μΑ
կլ	Logical "0" Input Current	V <sub>IN</sub> = 0V, V <sub>CC</sub> = Max		-0.1	-10	μА
lcc	Supply Current	All Outputs Low, VCC = Max		16	25	mA
VIC	Input Clamp Voltage	I <sub>IN</sub> = 10 mA			V <sub>CC</sub> +1.5V	V
		I <sub>IN</sub> = -10 mA			-1.5	v
tpd0	Propagation Delay to a Logical "0" From Any Input to Any Output	R <sub>L</sub> = 400Ω			10	μς
<sup>t</sup> pd1	Propagation Delay to a Logical "1" From Any Input to Any Output	C <sub>L</sub> = 50 pF T <sub>A</sub> = 25°C			10	μs

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range for the DS8669. All typicals are given for V<sub>CC</sub> = 5.25V and T<sub>A</sub> = 25°C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

<sup>\*</sup>Derate molded package 16.04 mW/° C above 25° C.

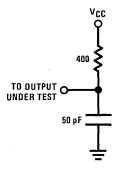
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Trı	ıth <sup>-</sup>	Tabl	е																
IN	PUT I	LEVE	LS						SEG	MENT	OUT	PUTS							
DN	CN	BN	AN	a1	b1	с1	d1	e1	f1	g1	a2	b2	c2	d2	e2	f2	g2	DISPLAY 1	DISPLAY 2
0	0	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	1		
0	0	0	1	1	0	0	1	1	1	1	1	0	0	1	1	1	1	' /	/
0	0	1	0	0	0	1	0	0	1	0	0	0	1	0	0	1	0	. <i>⊟</i>	,⊒′
0	0	1	1	0	0	0	0	1	1	0	0	0	0	0	1	1	0		∄
0	1	0	0	1	0	0	1	1	0	0	1	0	0	1	1	0	0	4	<i>'-</i> /
0	1	0	1	0	1	0	0	1	` o `	0	0	1	0	0	1	0	0	55	
0	1 -	1	0	0	1	0	0	0	0	0	0	1	0	0	0	0	0	5	5
0	1	1	1	0	0	0	1	1	1	1	0	0	0	1	1	1	1	7	7
1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	$\exists$	<u> </u>
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1	1	1	0	1	1	1	1	1	1	0	1	1	1	1	1	1	0	_	
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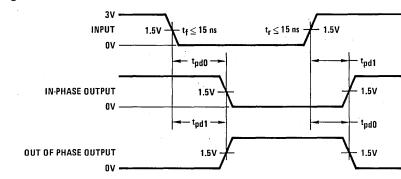
<sup>&</sup>quot;0" = Segment ON

Display Segment Notation

#### **AC Test Circuit**



#### **Switching Time Waveforms**



<sup>&</sup>quot;1" = Segment OFF



# DS8692, DS8693, DS8694 Printing Calculator Interface Set

#### **General Description**

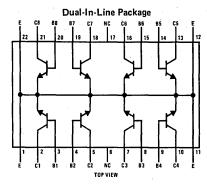
Two DS8692 IC's and one each of the DS8693 and DS8694 provide the complete interface necessary between the MM5787 calculator chip and the Seiko Model 310 printing head. The DS8692 is an array of eight common emitter output transistors each capable of sinking 350 mA, with open collector saturating outputs. The DS8693 contains the interface logic for the color solenoid driver, motor driver, and 7-column character select solenoid drivers. The DS8694 contains the interface logic for 8-column solenoid drivers plus the clock oscillator and timing signal buffer. The color and character select solenoid latch outputs of both are

constant current outputs supplying the base current for the DS8692 arrays. These outputs also feature active pull-down. The motor drive latch output is an open collector capable of sinking 20 mA.

#### **Features**

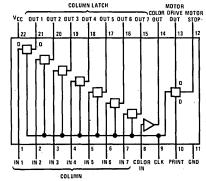
- Provides complete interface package for printing calculators with minimum number of packages and minimum number of external components
- 350 mA sink capability

#### Connection Diagrams



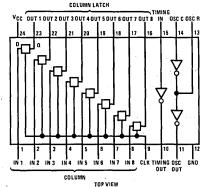
Order Number DS8692N See NS Package N22A

#### **Dual-In-Line Package**



Order Number DS8693N See NS Package N22A

#### Dual-In-Line Package



Order Number DS8694N See NS Package N24A

UNITS

°C

#### Absolute Maximum Ratings DS8692-Transistor Array (Note 1)

Collector to Base Voltage	25V	Power Dissipation ( $T_A = 25^{\circ}C$ )	650 mW
Collector to Emitter Voltage	25V	Operating Junction Temperature	150°C max
Collector to Emitter Voltage (Note 4)	15V	Operating Temperature Range	0°C to +70°C
Emitter to Base Voltage	6V	Storage Temperature Range	-65°C to +150°C
Collector Current (Continuous)	0.4A	Lead Temperature (Soldering, 10 seconds)	300°C

#### Electrical Characteristics DS8692 (Notes 2 and 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
VCEO	Collector to Emitter Breakdown Voltage	I <sub>C</sub> = 500 μA, I <sub>B</sub> = 0	15		MUTUL.	٧
VCES	Collector to Emitter Breakdown ' Voltage	I <sub>C</sub> = 1 mA, V <sub>BE</sub> = 0	25	,	V-10	٧
VCBO	Collector to Base Breakdown Voltage	IC = 1 mA, IE = 0	25		· · · · · · · · · · · · · · · · · · ·	٧
VCE(SAT)	Collector to Emitter Saturation Voltage	IC = 350 mA, IB = 7.0 mA, (Note 7)		0.6	1.0	V
V <sub>BE</sub> (SAT)	Base to Emitter Saturation Voltage	I <sub>C</sub> = 350 mA, I <sub>B</sub> = 7.0 mA, (Note 7)		0.8	1.05	V

#### Absolute Maximum Ratings DS8693 (Note 1) Operating Conditions DS8693

			MIN	MAX
Supply Voltage	12V	Supply Voltage (VCC)	8.5	11.0
Input Voltage	12V	Tomana vatura (T. )	•	+70
Output Voltage		Temperature (T <sub>A</sub> )	0	+70
All Pins Except Pin 13	12V	,		
Pin 13	19V			
Storage Temperature Range	-65°C to +150°C			
Maximum Power Dissipation* at 25°C				
Molded Package	1897 mW		•	
Lead Temperature (Soldering, 10 seconds)	300°C			

#### Electrical Characteristics DS8693 (Notes 2 and 3)

\*Derate molded package 15.18 mW/°C above 25°C.

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
COLUMN DI	RIVERS					
IIN	Input Current	V <sub>IN</sub> = 2.7V	50			μΑ
		V <sub>IN</sub> = 9.5V			250	μΑ
VOL	Output OFF Voltage	V <sub>CC</sub> = Min, V <sub>IN</sub> = 2.7V, V <sub>CLOCK</sub> = 3.5V, I <sub>OUT</sub> = 1 mA			0.4	V
IOH	Output ON Current	V <sub>CC</sub> = Min, V <sub>IN</sub> = 7.0V, V <sub>CLOCK</sub> = 3.5V, V <sub>OUT</sub> = 1.0V	7		-17	mA
los	Output Short Circuit Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 2.7V, V <sub>CLOCK</sub> = 3.5V, V <sub>OUT</sub> = 0V			-1.2	mA
CLOCK INPL	JT					
IIN	Input Current	V <sub>IN</sub> = 3.5V			300	μΑ
		V <sub>IN</sub> = 1.6V	50			μΑ
VIH	Logical "1" Input High Voltage		3.5			. V
VIL	Logical "0" Input Low Voltage				1.6	
MOTOR DRI	VER			<u> </u>	•	
IN(PRINT)	Input Current	V <sub>IN</sub> = 2.3V	50			μΑ
	t .	V <sub>IN</sub> = 9.5V			250	μA
IIL(STOP)	Input Low Current (Stop)	V <sub>CC</sub> = Min, V <sub>IN</sub> (STOP) = 0.4V, (Stop Switch Closed)			-700	μΑ
VIH(STOP)	Input High Voltage (Stop)	V <sub>CC</sub> = Max, I <sub>IN</sub> (STOP) = -10 μA, (Stop Switch Open)			2.5	V
VOL	Output Low Voltage	VCC = Min, VPRINT = 7V, IOUT = 15 mA			0.5	V

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
MOTOR DR	IVER (Continued)					
lox	Output Leakage Current	V <sub>CC</sub> = Max, V <sub>PRINT</sub> = 2.3V, V <sub>STOP</sub> = 0.8V, V <sub>OUT</sub> = 15V			100	μΑ
IH(STOP)	Logical "1" Input High Current				-10	μΑ
COLOR DR	IVER				· .	
IIN	Input Current	V <sub>1N</sub> = 3.5V		{	300	μΑ
•		V <sub>IN</sub> = 1.7V	50			μΑ
VOL	Output OFF Voltage	VCC = Min, VIN = 1.7V, IOUT = 1 mA			0.4	V
ЮН	Output ON Current	V <sub>CC</sub> = Min, V <sub>IN</sub> = 3.5V, V <sub>OUT</sub> = 1.0V	-8		-18	mA
ICC(SB)	Stand-by Supply Current, (Note 6)	VCC = Max, VCOLUMN IN/VPRINT = 0V, VCOLOR = 0V, VCLOCK = 3.5V			. 55	mA

<b>Absolute Maximum Ratir</b>	Operating Conditions DS8694					
Supply Voltage	12V		MIN	MAX	UNITS	
Input Voltage All Pins Except Pin 15	12V	Supply Voltage (V <sub>CC</sub> )	8.5	11.0	V	
Pin 15	19V	Temperature (T <sub>A</sub> )	0	+70	°C	
Output Voltage	12V					
Storage Temperature Range	65°C to +150°C					
Maximum Power Dissipation* at 25°C		•				
Molded Package	2005 mW					
Lead Temperature (Soldering, 10 seconds)	300°C					
*Derate molded package 16.04 mW/°C above	25° C.					

# Electrical Characteristics DS8694 (Notes 2 and 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
COLUMN	DRIVER					
IIN	Input Current	V <sub>IN</sub> = 2.7V			50	μА
	<u> </u>	V <sub>IN</sub> = 9.5V			250	μΑ
VOL	Output OFF Voltage	V <sub>CC</sub> = Min, V <sub>IN</sub> = 2.7V, V <sub>CLOCK</sub> = 3.5V, I <sub>OUT</sub> = 1 mA			0.4	V
ЮН	Output ON Current	V <sub>CC</sub> = Min, V <sub>IN</sub> = 7.0V, V <sub>CLOCK</sub> = 3.5V, V <sub>OUT</sub> = 1.0V	-7		-17	mA
los	Output Short-Circuit Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 2.7V, V <sub>CLOCK</sub> = 3.5V, V <sub>OUT</sub> = 0V			-1.2	mA
CLOCK IN	PUT					
IIN	Input Current	V <sub>IN</sub> = 3.5V			300	μА
		V <sub>IN</sub> = 2.7V	50			μΑ
VIH	Logical "1" Input High Voltage		3.5			V
VIL	Logical "0" Input Low Voltage				1.6	V
TIMING B	UFFER					
IIN	Input Current	V <sub>1N</sub> = 2V			-50	μА
		V <sub>IN</sub> = 17V			880	μΑ
V <sub>OL</sub>	Output Low Voltage	I <sub>OUT</sub> = 50 μA, V <sub>IN</sub> = 10V			0.5	V
Voн	Output High Voltage	I <sub>OUT</sub> = -50 μA, V <sub>IN</sub> = 7V	V <sub>CC</sub> -1.0			V
OSCILLAT	OR		·············			
fosc	Frequency	V <sub>CC</sub> = Max, R = 18k, C = 0.0015 μFd, (Note 5)	85	100	115	kHz
VOL	Output Low Voltage	V <sub>CC</sub> = Min, t <sub>OUT</sub> = 50 μA			0.5	V
Voн	Output High Voltage	I <sub>OUT</sub> = -50 μA	V <sub>CC</sub> -1.0			V
DC	Duty Cycle	VCC = Max	40	50	60	%
Vosc	Osc. VCC Turn ON Voltage		6.0	7.7	8.5	V
ICC(SB)	Stand-by Supply Current	V <sub>CC</sub> = Max, V <sub>COLUMN</sub> IN/ V <sub>PRINT</sub> = 0V, I <sub>CLOCK</sub> = 300 μA	-		55	mA

# Switching Characteristics DS8694

 $V_{CC} = 5V$ ,  $T_A = 25^{\circ}C$  (unless otherwise specified)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
COLUMN DRIV	/ERS (DS8693, DS8694) (Figure 3)					
PWCOLUMN	Column In Pulse Width		1.1			μs
PWCLOCK	Clock Pulse Width		1.0			μs
td	Delay of Column In Pulse After Clock Transitions to Low State For Output to Latch		0.1			μς
tPD0	Propagation Delay to a Logical "O" From Clock to Column Out Output	Column In = 0V			10.0	μs
tPD1	Propagation Delay to a Logical "1" From Clock to Column Output	Column In = 7V			1300	μς
tPD0	Propagation Delay to a Logical "0" From Column In to Column Out	Clock = 7V		-	10	μς
<sup>t</sup> PD1	Propagation Delay to a Logical "1" From Column In to Column Out	Clock = 7V			1300	μs
COLOR DRIVE	R (DS8693) (Figure 4)				<del></del>	<u> </u>
tPD0	Propagation Delay to a Logical "O" From Color In to Color Out				10.0	μς
tPD1	Propagation Delay to a Logical "1" From Color In to Color Out				10.0	μς
MOTOR DRIVE	ER (DS8693) (Figure 6)		ال المساول		· · · · · · · · · · · · · · · · · · ·	
PWPRINT	Print Signal Pulse Width		1			μs
PWSTOP	Stop Signal Pulse Width		1			μs
PWCLOCK	Clock Pulse Width		1			μs
tPD0	Propagation Delay to a Logical "O" From Print to Motor Drive Out				10	μς
tPD1	Propagation Delay to a Logical "1" From Motor Stop (High-to- Low Transition) to Motor Drive Out	Print = 0V, Clock = 7.0V			10	μς
TIMING SIGNA	L BUFFER (DS8694) (Figure 5)					
PWTIMING	Timing Signal Pulse Width		1	1000		ms
t <sub>r</sub>	Rise Time	CLOAD = 35 pF			500	ns
tf	Fall Time	CLOAD = 35 pF			500	ns
<sup>t</sup> PD0	Propagation Delay to a Logical "O" From Timing In to Timing Out				10	μς
tPD1	Propagation Delay to a Logical "1" From Timing In to Timing Out				10	μs
CLOCK OSCILI	ATOR (DS8694) (Figure 7)					
fosc	Oscillator Frequency	(Note 5)	85.	100	115	kHz
DC	Duty Cycle		40	50	60	%
tr	Rise Time	CLOAD = 70 pF			500	ns
tr	Fall Time	C <sub>LOAD</sub> = 70 pF			500	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8692, DS8693, DS8694. All typicals are given for  $V_{CC} = 10V$  and  $T_A = 25^{\circ}$ C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute basis.

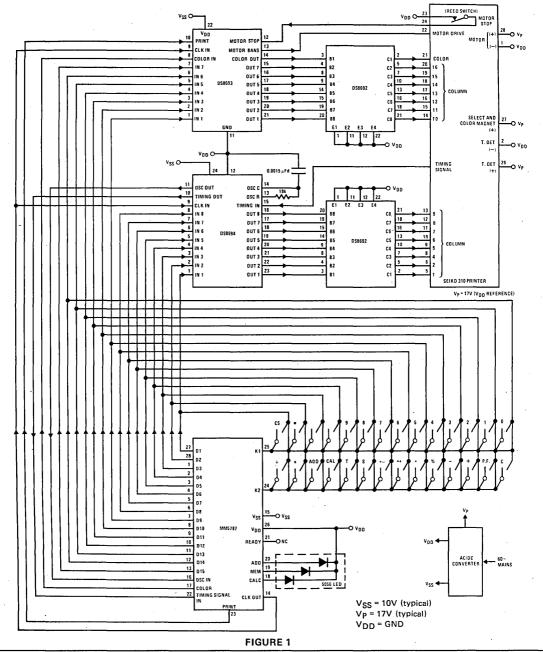
Note 4: Ratings refer to a high current point where collector-emitter voltage is lowest.

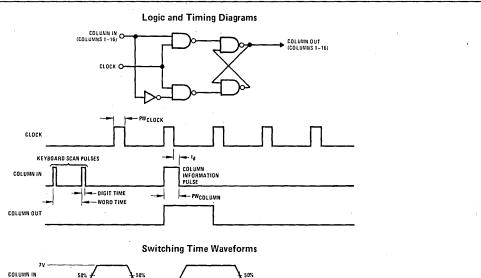
Note 5: Oscillator frequency is determined by external R between "Osc R" and "Osc C" and external C from "Osc C" to ground, 2k > R > 20k,

Note 6: Column outputs operate on approximately 1/16 duty cycle in normal operation.

Note 7: Measured with one output on at a time.

#### **System Connection Diagram**





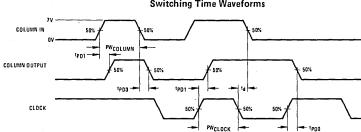


FIGURE 3. DS8693, DS8694 Column Latch

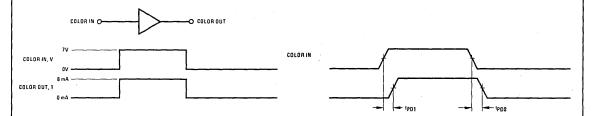


FIGURE 4. DS8693 Color Driver

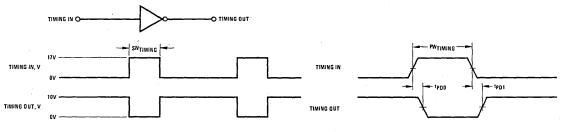
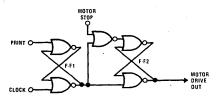
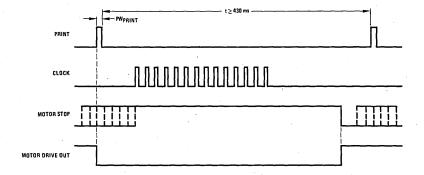


FIGURE 5. DS8694 Timing Signal Buffer

#### Logic and Timing Diagrams





#### **Switching Time Waveforms**

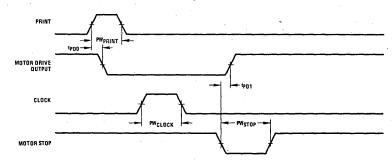


FIGURE 6. DS8693 Motor Drive Latch

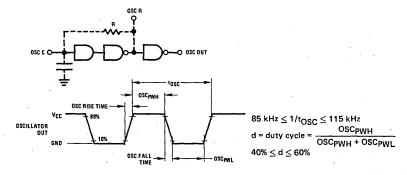


FIGURE 7. DS8694 Oscillator Diagram

# DS8859A, DS8869A Open Collector Hex Latch LED Drivers

#### **General Description**

The DS8859A, DS8869A are TTL compatible open collector hex latch LED drivers with programmable current sink outputs. The current sinks are nominally set at 14 mA but may be adjusted by external resistors for any value between 0-32 mA. Each device contains six latches which may be set by input data terminals. An active low strobe common to all six latches enables the data input terminals. The DS8859A current sink outputs are switched on by entering a high level into the latches and the DS8869A current sink outputs are switched on by entering a low level into the latches.

The devices are available in either a molded or cavity package. In order not to damage the devices there is a limit placed on the power dissipation allowable for each package type. This information is shown in the graph included in this data sheet.

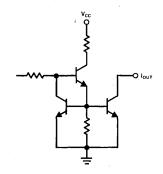
#### **Features**

- Built-in latch
- Programmable output current
- TTL compatible inputs
- 32 mA output sink

#### Logic Diagram

# DS8859 INPUT DATA 1 CURRENT C TO OTHER CURRENT

#### **Output Circuit**



#### **Connection Diagram**

# IADJ INPUT 1 OUTPUT 1 INPUT 2 OUTPUT 2 INPUT 3 OUTPUT 3

TOP VIEW

Dual-In-Line Package

#### **Truth Table**

COMMON STROBE	INPUT DATA	DS8859 OUTPUT (t + 1)	DS8869 OUTPUT (t + 1)
0	0	OFF	ON
0	1	ON	OFF
1	X	OUTPUT (t)	OUTPUT (t)

Order Number DS8859AJ, DS8869AJ, **DS8859AN or DS8869AN** See NS Package J16A or N16A

Molded Package

#### Absolute Maximum Ratings (Note 1)

### **Operating Conditions**

	MIN	MAX	UNITS
Supply Voltage, V <sub>CC</sub>	4.75	5.25	V
Temperature, T <sub>A</sub>	0	+70	°c

Supply Voltage	7V
Input Voltage	5.5V
Output Voltage	5.5V
Storage Temperature Range	-65°C to +150°C
Maximum Power Dissipation* at 25°C	
Cavity Package	1433 mW

<sup>\*</sup>Derate cavity package 9.55 mW/°C above 25°C; derate molded package 10.9 mW/°C above 25°C.

Lead Temperature (Soldering, 10 seconds)

#### Electrical Characteristics (Notes 2 and 3)

PARAMETER		CONI	CONDITIONS		TYP	MAX	UNITS
V <sub>IH</sub>	Logical "1" Input Voltage	V <sub>CC</sub> = Min	V <sub>CC</sub> = Min				٧
I <sub>IH</sub>	Logical "1" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 2.4V	V <sub>CC</sub> = Max, V <sub>IN</sub> = 2.4V			40	μΑ
V <sub>IL</sub>	Logical "0" Input Voltage	V <sub>CC</sub> = Min	V <sub>CC</sub> = Min			0.8	٧
I <sub>IL</sub>	Logical "0" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V		-1.0	-1.6	mA
V <sub>CD</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -12 mA			-1.1	-1.5	٧
I <sub>oH</sub>	Logical "1" Output Current	V <sub>CC</sub> = Min, V <sub>IL</sub> = 0.8V, V <sub>OH</sub> =	V <sub>CC</sub> = Min, V <sub>IL</sub> = 0.8V, V <sub>OH</sub> = 5.5V, V <sub>IH</sub> = 2.0V			250	μΑ
V <sub>OL</sub>	Logical "0" Output Voltage	$V_{CC}$ = Min, $V_{IL}$ = 0.8V, $I_{OL}$ = $V_{IH}$ = 2V, $V_{IADJ}$ = $V_{CCMIN}$	$V_{CC} = Min, V_{IL} = 0.8V, I_{OL} = 16 \text{ mA},$ $V_{IH} = 2V, V_{IADJ} = V_{CCMIN}$			0.4	٧
I <sub>cc</sub>	Supply Current	V <sub>CC</sub> = Max, Current Sources " (See Truth Table), (Note 4)	OFF,"			50	mA
Isink	Output Current	V <sub>CC</sub> = 5.0V, V <sub>OUT</sub> = 2.0V,	V <sub>IADJ</sub> = 5V	32			mA
		$T_{\Delta} = 25^{\circ}C$ , (Note 4)	I <sub>ADJ</sub> = Open	9	14	26	mΑ

1362 mW

300°C

#### Switching Characteristics $T_A = 25^{\circ}C$ , $V_{CC} = 5V$

PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
t <sub>pd0</sub> Propagation Delay to a Logical "0"		Data to Output			36	ns
	$C_{OUT} = 15 pF, R_L = 390\Omega,$	Strobe to Output			50	ns
t <sub>pd1</sub> Propagation Delay to a Logical "1"	(Note 5)	Data to Output			150	ns
		Strobe to Output			150	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

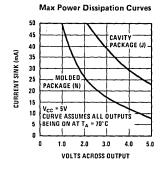
Note 2: Unless otherwise specified min/max limits apply across the  $0^{\circ}$ C to +70°C temperature range. All typicals are given for  $V_{CC}$  = 5.0V and  $T_{A}$  = 25°C.

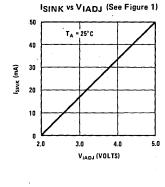
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

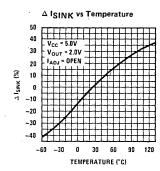
Note 4: See graphs for changes in ISINK versus changes in temperature and VCC.

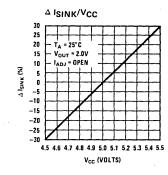
Note 5: COUT includes device output capacitance of approximately 8.5 pF and wiring capacitance.

#### **Typical Performance Characteristics**

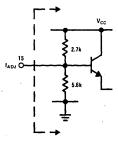








# I<sub>SINK</sub> Adjustment Circuit



IADJ may be programmed by a voltage source or by resistors.

FIGURE 1.



# DS8861 MOS-to-LED 5-Segment Driver DS8863 MOS-to-LED 8-Digit Driver DS8963 MOS-to-LED 8-Digit Driver

#### **General Description**

The DS8861, DS8863 and DS8963 are designed to be used in conjunction with MOS integrated circuits and common-cathode LED's in serially addressed multi-digit displays.

The DS8861 is a 5-segment driver capable of sinking or sourcing up to 50 mA from each driver.

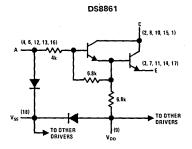
The DS8863 is an 8-digit driver. Each driver is capable of sinking up to 500 mA.

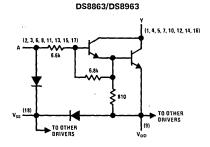
The DS8963 is identical to the DS8863 except it is intended for operation at up to 18V.

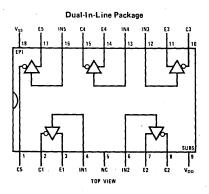
#### **Features**

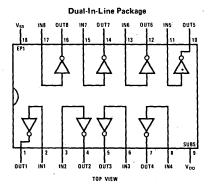
- 50 mA source or sink capability per driver, DS8861
- 500 mA sink capability per driver, DS8863, DS8963
- MOS compatibility (low input current)
- Low standby power
- High gain Darlington circuits

#### **Schematic and Connection Diagrams**









Order Numbers DS8861N, DS8863N or DS8963N See NS Package N18A

#### **Absolute Maximum Ratings**

	DS8861	DS8863	DS8963
Input Voltage Range (Note 1)	-5V to V <sub>SS</sub>	-5V to V <sub>SS</sub>	-5V to V <sub>SS</sub>
Collector (Output) Voltage (Note 2)	_ 10V	10V	18V
Collector (Output)-to-Input Voltage	10V	10 <sub>.</sub> V	18V
Emitter-to-Ground Voltage (V <sub>I</sub> > 5V)	10V		
Emitter-to-Input Voltage	5V		
Voltage at V <sub>SS</sub> Terminal With Respect to Any Other Device Terminal	10V	10V	18V
Collector (Output) Current			
Each Collector (Output)	50 mA	500 mA	500 mA
All Collectors (Output)	200 mA	600 mA	600 mA
Continuous Total Dissipation	800 mW	800 mW	800 mW
Operating Temperature Range	0°C to +70°C	0°C to +70°C	$0^{\circ}$ C to $+70^{\circ}$ C
Storage Temperature Range	−65°C to +150°C	-65°C to +150°C	-65°C to +150°C
Maximum Power Dissipation at 25°C			
Molded Package	1476 mW *	1563 mW <sup>†</sup>	1563 mW <sup>†</sup>
Lead Temperature (Soldering, 10 sec)	300°C	300°C	300°C

<sup>\*</sup>Derate molded package 11.81 mW/° C above 25° C.

# Electrical Characteristics DS8861 ( $V_{SS} = 10V$ , $T_A = 0^{\circ}C$ to +70°C unless otherwise noted)

	PARAMETER	COND	OITIONS		MIN	TYP	MAX	UNITS
V <sub>CEON</sub>	"ON" State Collector Emitter Voltage	Input = 8V through 1 I <sub>C</sub> = 50 mA	$k\Omega$ , $V_E = 5V$ ,	T <sub>A</sub> = 25°C		0.9	1.2	V V
ICOFF	"OFF" State Collector Current	V <sub>C</sub> = 10V, V <sub>E</sub> = 0	$I_{1N} = 40\mu A$ $V_{1N} = 0.7V$				100 100	μA μA
I <sub>1</sub>	Input Current at Maximum Input Voltage	V <sub>IN</sub> = 10V, V <sub>E</sub> = 0, I	c = 20 mA -			2.2	3.3	mA
I <sub>1</sub>	Emitter Reverse Current	V <sub>IN</sub> = 0, V <sub>E</sub> = 5V, I <sub>C</sub>	= 0				100	μΑ
1.,5	Current Into V <sub>SS</sub> Terminal						1	mA

#### DS8863/DS8963 ( $V_{SS} = 10V$ , $T_A = 0^{\circ}C$ to +70°C unless otherwise noted)

PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS	
VoL	Low Level Output Voltage	V - 7V I	- 500 4	T <sub>A</sub> = 25°C			1.5	V
,		$V_{IN} = 7V, I_{OU}$	T = 500 mA				1.6,	V
Іон	High Level Output Current	101/1	$I_{1N} = 40\mu A$ $V_{1N} = 0.5V$				250	μΑ
	<u> </u>	V <sub>OH</sub> = 10V*	V <sub>IN</sub> = 0.5V		1		250	μΑ
1,	Input Current at Maximum Input Voltage	V <sub>IN</sub> = 10V, I <sub>O</sub>	<sub>L</sub> = 20 mA				2	mA
Iss	Current Into V <sub>SS</sub> Terminal					, ,	1	mA

<sup>\*18</sup>V for the DS8963

# Switching Characteristics DS8861 ( $V_{SS} = 7.5V$ , $T_A = 25^{\circ}C$ )

<u></u>	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High Level Output (Collector)	V <sub>IH</sub> = 4.5V, V <sub>E</sub> = 0		100		ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low Level Output (Collector)	$R_L = 200\Omega, C_L = 15 pF$		20		ns

#### DS8863/DS8963 ( $V_{SS} = 7.5V, T_A = 25^{\circ}C$ )

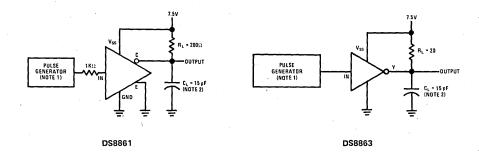
į	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
ł	t <sub>PLH</sub> Propagation Delay Time, Low-to-High Level Output	$V_{IH}$ = 8V, $R_L$ = 20 $\Omega$ ,		300		ns
į	t <sub>PHL</sub> Propagation Delay Time, High-to-Low Level Output	C <sub>L</sub> = 15 pF		30		ns

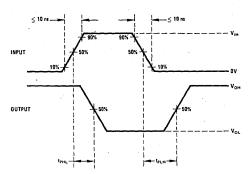
Note 1: The input is the only device terminal which may be negative with respect to ground.

Note 2: Voltage values are with respect to network ground terminal unless otherwise noted.

<sup>&</sup>lt;sup>†</sup>Derate molded package 12.5 mW/° C above 25° C.

# **AC Test Circuits and Waveforms**





NOTE 1: THE PULSE GENERATOR HAS THE FOLLOWING CHARACTERISTICS:  $Z_{OUT}$  = 50 $\Omega$ , prr = 100 kHz,  $t_W$  = 1 $\mu$ E. Note 2:  $C_L$  includes probe and Jig capacitance.

# **DS8867 8-Segment Constant Current Driver**

#### **General Description**

The DS8867 is an 8-segment driver designed to be driven from MOS circuits operating at 8V ±10% minimum V<sub>SS</sub> supply and will supply 14 mA typically to an LED display. The output current is insensitive to V<sub>CC</sub> varia-

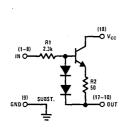
#### **Features**

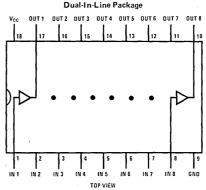
Internal current control—no external resistors

**Display Controllers/Drivers** 

- 100% efficient, no standby power
- Operates in three and four cell battery systems
- Inputs and outputs grouped for easy PC layout

#### **Schematic and Connection Diagrams**

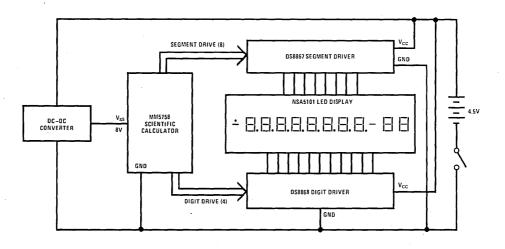




Order Number DS8867N See NS Package N18A

#### **Typical Application**

Typical 3 Cell Scientific Calculator Circuit



#### Absolute Maximum Ratings (Note 1)

#### **Operating Conditions**

			MIN	MAX	UNITS
Supply Voltage	7V	Supply Voltage, VCC	3.3	6.0	V
Input Voltage	10V				0.0
Output Voltage	10V	Temperature, T <sub>A</sub>	U	+70	°C
Storage Temperature Range	–65°C to +150°C				
Maximum Power Dissipation* at 25°C	•				
Molded Package	1345 mW				
Lead Temperature (Soldering, 10 seconds)	300° C				

#### **Electrical Characteristics** (Note 2)

\*Derate molded package 10.76 mW/° C above 25° C.

	PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	Logical "1" Input Voltage	V <sub>CC</sub> = Min, V	OH = 2.3V, I <sub>IH</sub> = 500μA		4.9	5.4	V
1 <sub>1L</sub>	Logical "0" Input Current	V <sub>CC.</sub> = Max, V	<sub>OL</sub> = 1.8V, V <sub>IL</sub> = 2.0V		0.1	10	μΑ
I <sub>OH</sub>	Logical "1" Output Current	V <sub>CC</sub> = Min, V	V <sub>CC</sub> = Min, V <sub>OH</sub> = 2.3V, I <sub>IH</sub> = 500μA		-14	-18	mA
IoL	Logical "0" Output Current	V <sub>CC</sub> = Max, V	V <sub>OL</sub> = 1.0V, V <sub>IL</sub> = 1.3V		-0.5	-10	μΑ
I <sub>CC OFF</sub>	Supply Current	V <sub>CC</sub> = Max.	All V <sub>OL</sub> = 1.0V, V <sub>1L</sub> = 1.3V, (Standby)		4	50	μΑ
I <sub>CC ON</sub>		V <sub>CC</sub> - Wax.	All V <sub>OH</sub> = 2.3V, V <sub>IH</sub> = 7.8V		112	150	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C.

# **DS8870 Hex LED Digit Driver**

#### **General Description**

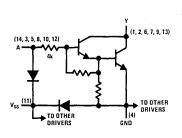
The DS8870 is an interface circuit designed to be used in conjunction with MOS integrated circuits and commoncathode LED's in serially addressed multi-digit displays. The number of drivers required for this time-multiplexed system is minimized as a result of the segment-address-and-digit-scan method of LED drive.

#### **Features**

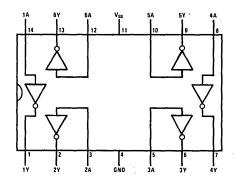
- Sink capability per driver-350 mA
- MOS compatibility (low input current)
- Low standby power
- High-gain Darlington circuits

#### **Schematic and Connection Diagrams**

DS8870 (Each Driver)



Dual-In-Line Package



Order Number DS8870J or DS8870N See NS Package J14A or N14A above 25°C.

#### Absolute Maximum Ratings (Note 1)

Input Voltage Range (Note 4)	−5V to V <sub>SS</sub>
Collector Output Voltage	10V
Collector Output to Input Voltage	10V
Voltage at V <sub>SS</sub> Terminal with Respect to	
Any Other Device Terminal	10V
Collector Output Current	
Each Collector Output	350 mA
All Collector Outputs	600 mA
Continuous Total Dissipation	800 mW
Operating Temperature Range	$0^{\circ}$ C to $+70^{\circ}$ C
Storage Temperature Range	−65°C to +150°C
Maximum Power Dissipation* at 25°C	
Cavity Package	1308 mW
Molded Package	1207 mW
Lead Temperature (Soldering, 10 seconds)	300°C
*Derate cavity package 8.72 mW/°C above 25°C; derate r	nolded package 9.66 mW/°

# Electrical Characteristics (V<sub>SS</sub> = 10V) (Notes 2 and 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>OL</sub>	Low Level Output Voltage	Input = 6.5V through 1 k $\Omega$ , I <sub>OUT</sub> = 350 mA, T <sub>A</sub> = 25 $^{\circ}$ C		1.2	1.4	٧
V <sub>OL</sub>	Low Level Output Voltage	Input = 6.5V through 1 k $\Omega$ , $I_{OUT} = 350 \text{ mA}$			1.6	· V
I <sub>OH</sub>	High Level Output Current	V <sub>OH</sub> = 10V, I <sub>IN</sub> = 40μA			200	μΑ
l <sub>он</sub>	High Level Output Current	V <sub>OH</sub> = 10V, V <sub>IN</sub> = 0.5V			200	· μA
l <sub>l</sub>	Input Current at Maximum Input Voltage	.V <sub>IN</sub> = 10V, I <sub>OL</sub> = 20 mA		2.2	3.3	mA
I <sub>SS</sub>	Current Into V <sub>SS</sub> Terminal				1	mA

# Switching Characteristics ( $V_{SS} = 7.5V$ , $T_A = 25^{\circ}C$ )

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>PLH</sub> Propagation Delay Time, Low-to-High Level Output	$V_{IH} = 7.5V, R_{L} = 39\Omega,$ $C_{L} = 15 pF$		300		ns
t <sub>PHL</sub> Propagation Delay Time, High-to-Low Level Output	$V_{IH}$ = 7.5V, $R_L$ = 39 $\Omega$ , $C_L$ = 15 pF		30		ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C temperature range.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: The input is the only device terminal which may be negative with respect to ground.



# DS8871, DS8872, DS8873 Saturating LED Cathode Drivers

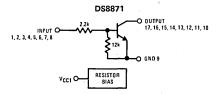
#### **General Description**

The DS8871, DS8872, and DS8873 are bipolar integrated circuits designed to interface between MOS calculator circuits and common cathode LED displays operating in the multiplexed mode with a digit current of up to 40 mA. The DS8871 is an 8-digit driver; the DS8872 is a 9-digit driver; and the DS8873 is a 9-digit driver with a built-in battery condition indicator that turns on the digit 9 decimal point when the battery voltage drops to 6.5V (typical). In a typical calculator system operating on a 9V battery, the low battery indicator comes on as a warning that the battery should be replaced. But the calculator (MM5737 or equivalent) will still function properly for awhile.

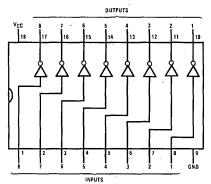
#### **Features**

- Single saturating transistor output
- Low battery indicator
- MOS compatible inputs
- Inputs and outputs clustered for easy wiring
- Drivers consume no standby power

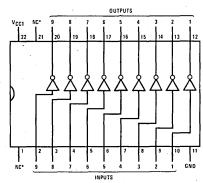
#### Schematic Diagram



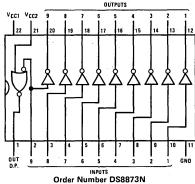
#### Connection Diagrams (Dual-In-Line Packages, Top Views)



Order Number DS8871N See NS Package N18A



Order Number DS8872N See NS Package N22A



See NS Package N22A

#### Absolute Maximum Ratings (Note 1) **Operating Conditions** UNITS MAX 9.5 Supply Voltage V<sub>CC1</sub> = 11V Supply Voltage, V<sub>CC1</sub> 4 0 V<sub>CC2</sub> = 11V Supply Voltage (Note 4) v Supply Voltage, VCC2 (Note 4) 4.0 9.5 Input Voltage 11V °c +70 Temperature, TA 8V Output Voltage -65°C to +150°C Storage Temperature Range Maximum Power Dissipation at 25°C Molded Package (DS8871) 1563 mW Molded Package (DS8872, DS8873)† 1771 mW 300°C Lead Temperature (Soldering, 10 seconds) \*Derate molded package 12.5 mW/°C above 25°C.

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
IJĹ	Logical "0" Input Current	V <sub>IN</sub> = 0.4V		28	45	μΑ
IIH	Logical "1" Input Current	V <sub>IN</sub> = 4.5V		1.7	2.5	mA
VOL	Logical "0" Output Voltage	V <sub>IN</sub> = 3.2V, I <sub>OL</sub> = 40 mA		0.35	0.5	٧
loL	Logical "0" Output Current	V <sub>IN</sub> = 3.2V, V <sub>OL</sub> = 0.5V	-		40	mA
ICEX	Output Leakage Current	V <sub>OH</sub> = 6V, I <sub>IN</sub> = 25 μA			40	μΑ
1DP(ON)	Decimal Point Output Current	V <sub>CC2</sub> = 6.25V, V <sub>DP</sub> = 2.5V, V <sub>IN9</sub> = 3.2V, (Note 4)	-5.0	-7.0		mA
IDP(OFF)	Decimal Point Output Current	V <sub>CC2</sub> = 7V, V <sub>IN9</sub> = 3.2V, V <sub>DP</sub> = 1V, (Note 4)	1	-1	-100	μΑ
ICC1	Supply Current, VCC1	V <sub>CC1</sub> = 6.5V, V <sub>IN</sub> = 0V		1	100	μА
I <sub>CC2</sub>	Supply Current, VCC2	VCC2 = 9.5V, V <sub>1N9</sub> = 4.5V, (Note 4)		0.9	1.2	mA

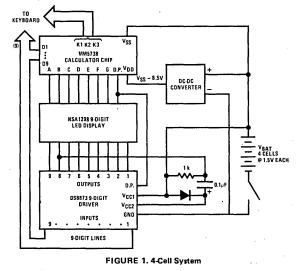
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Applies to DS8873 only.

#### **Typical Applications**



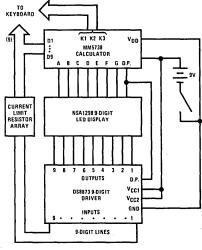


FIGURE 2. 9V System

<sup>&</sup>lt;sup>†</sup>Derate molded package 14.17 mW/°C above 25°C.

# **DS8874 9-Digit Shift Input LED Driver**

#### **General Description**

The DS8874 is a 9-digit LED driver which incorporates a shift register input decoding circuit and a low battery indicator. Outputs will sink 110 mA at less than 0.5V drop when sequentially selected. When the VCC supply falls below 6.5V typical, segment current will be furnished at digit 9 time to indicate a low battery condition. Pin 13 is generally connected to the decimal point segment on the display so that when a low battery condition exists, the left-most decimal point lights up. The digit driver is intended to be used with the

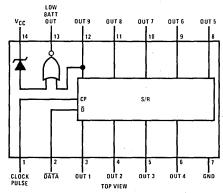
MM5784N 5-function, 9-digit accumulating memory calculator circuit, or any other circuit which supplies the 9-digit information in a similar serial format.

#### **Features**

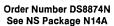
- 110 mA digit sink
- Low battery indicator
- Minimum number of connections
- MOS compatible inputs

#### **Connection Diagram**

# Diagram Equivalent Schematic



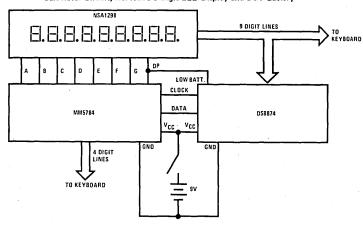
Dual-In-Line Package



# INPUT O OUTPUT

#### **Typical Application**

Typical Application of the DS8874 Digit Driver with the MM5784 5-Function Calculator Circuit, NSA1298 9-Digit LED Display and a 9V Battery



#### Absolute Maximum Ratings (Note 1)

#### **Operating Conditions**

Supply Voltage	10V
Input Voltage	3V
Output Voltage	10V
Storage Temperature Range	-65° C to +150° C
Maximum Power Dissipation* at 25°C	

Supply Voltage ( $V_{CC}$ ) 6.0 Temperature ( $T_A$ ) 0

MIN MAX UNITS 6.0 9.5 V 0 +70 °C

Molded Package Lead Temperature (Soldering, 10 seconds) 1280 mW 300° C

\*Derate molded package 10.24 mW/°C above 25°C.

#### Electrical Characteristics (Notes 2 and 3)

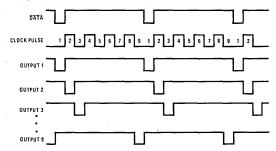
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
ЧH	Logical "1" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 3V		0.25	0.4	mA
HL s	Logical "0" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.8V		0.05	0.1	mA
VCCL	Decimal Point "ON"	$V_{dp} = 2.3V$ , $I_{dp} = -4$ mA, $O9 = V_{OL}$		ļ	6.0	V
Vссн	Decimal Point "OFF"	$V_{dp} = 1V$ , $I_{dp} = -10\mu A$ , $O9 = V_{OL}$	7.0	1		V
Юн	Logical "1" Output Current	V <sub>CC</sub> = Max, Output Not Selected		j	100	μΑ
VOL	Logical "0" Output Voltage	V <sub>CC</sub> = Min, Output Selected, I <sub>O1</sub> = 80 mA V <sub>CC</sub> = Max, Output Selected, I <sub>O1</sub> = 110 mA		0.45 0.6	1 1.5	V V
Icc	Supply Current	V <sub>CC</sub> = Max, One Output Selected	1	13	19	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range. All typicals are given for TA = 25°C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

#### Timing Diagram (Upper Level More Positive)



# **DS8877 6-Digit LED Driver**

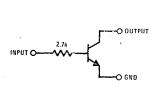
#### **General Description**

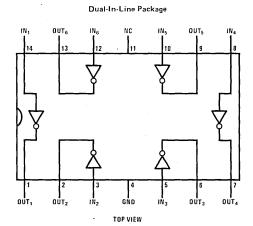
The DS8877 is a 6-digit LED driver designed as a pinfor-pin replacement for the DS75492 in applications where digit current is in the 5 to 50 mA range. Since the outputs saturate to less than 0.6V, the DS8877 will work on lower battery voltages than most digit drivers. The DS8877 draws no standby power.

#### **Features**

- No standby power
- No supply connection
- Operates in 4.5V,6V or 9V systems
- Pin-for-pin replacement for DS75492 in low current applications

#### **Logic and Connection Diagrams**





Order Number DS8877N See NS Package N14A

#### **Absolute Maximum Ratings** (Note 1)

Supply Voltage
Input Voltage
Input Voltage
Output Voltage
10V
Operating Temperature Range
Storage Temperature Range
Maximum Power Dissipation\* at 25°C
Molded Package
In 6 mW
Lead Temperature (Soldering 10 seconds)
300°C

Lead Temperature (Soldering, 10 seconds)
\*Derate molded package 8.85 mW/° C above 25° C.

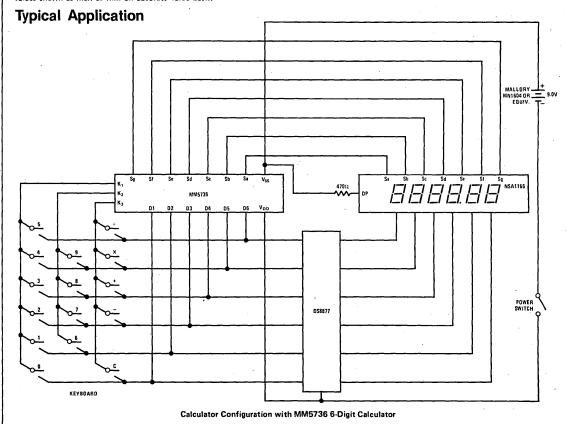
#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	Logical "1" Input Voltage		5.0			V
I <sub>IH</sub>	Logical "1" Input Current	V <sub>IH</sub> = 5.0V			1.2	mA
V <sub>IL</sub>	Logical "0" Input Voltage				0.35	V
I <sub>L</sub>	Logical "0" Input Current	V <sub>IL</sub> = 0.35V			20	μΑ
ICEX	Logical "1" Output Current	$V_C = 8.0V$ , $V_{IN} = 0.35V$			100	μΑ
VoL	Logical "0" Output Voltage	I <sub>OL</sub> = 35 mA, V <sub>IN</sub> = 5.0V			0.5	V
loL	Logical "0" Output Current	V <sub>OL</sub> = 0.5V, V <sub>IN</sub> = 5.0V	35	50		mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range. All typicals are given for TA = 25°C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.





## **Display Controllers/Drivers**

## DS7880/DS8880 High Voltage 7-Segment Decoder/Driver

#### **General Description**

The DS7880/DS8880 is custom designed to decode four lines of BCD and drive a gas-filled seven-segment display tube.

Each output constitutes a switchable, adjustable current sink which provides constant current to the tube segment, even with high tube anode supply tolerance or fluctuation. These current sinks have a voltage compliance from 3V to at least 80V; typically the output current varies 1% for output voltage changes of 3 to 50V. Each bit line of the decoder switches a current sink on or off as prescribed by the input code. Each current sink is ratioed to the b-output current as required for even illumination of all segments.

Output currents may be varied over the 0.2 to 1.5 mA range for driving various tube types or multiplex operation. The output current is adjusted by connecting an external program resistor

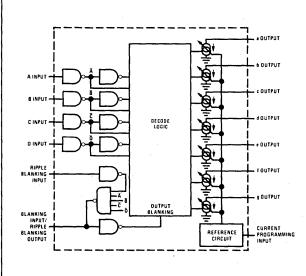
(R<sub>p</sub>) from V<sub>CC</sub> to the Program input in accordance with the programming curve. The circuit design provides a one-to-one correlation between program input current and b-segment output current.

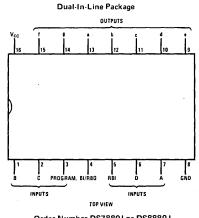
The Blanking Input provides unconditional blanking of any output display, while the Ripple Blanking pins allow simple leading or trailing-zero blanking.

#### **Features**

- Current sink outputs
- Adjustable output current 0.2 to 1.5 mA
- High output breakdown voltage 110V typ
- Suitable for multiplex operation
- Blanking and Ripple Blanking provisions
- Low fan-in and low power

## **Logic and Connection Diagrams**





Order Number DS7880J or DS8880J Order Number DS8880N See NS Package J16A or N16A

Absolute Maximum Ratin	<b>gs</b> (Note 1)		Operating Conditions						
				MIN	MAX	UNITS			
Vcc	7V	:	Supply Voltage (VCC)						
Input Voltage (Except BI)	6V		DS7880	4.5	5.5	V			
Input Voltage (BI)	Vcc		D\$8880	4.75	5.25	V			
Segment Output Voltage	80V	`	Temperature (T <sub>A</sub> )						
Power Dissipation	600 mW		DS7880	-55	+125	" С			
Transient Segment Output Current (Note 4)	50 mA	1.	DS8880	0	+70	C			
Storage Temperature Range	-65°C to +150°C								
Maximum Power Dissipation* at 25°C	•								
Cavity Package	1509 mW								
Molded Package	1476 mW								
Lead Temperature (Soldering, 10 sec)	300°C								

## Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDI	TIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	Logical "1" Input Voltage	V <sub>CC</sub> = Min		2.0			٧
VIL	Logical "0" Input Voltage	V <sub>CC</sub> = Min	· · · · · · · · · · · · · · · · · · ·			0.8	V
VoH	Logical "1" Output Voltage	V <sub>CC</sub> = Min, I <sub>OUT</sub> = -200μ	2.4	3.7		V	
Vol	Logical "0" Output Voltage	V <sub>CC</sub> = Min, I <sub>OUT</sub> = 8 mA,		0.13	0.4	V	
Life	Logical "1" Input Current		V <sub>IN</sub> = 2.4V		2	15	μΑ
		V <sub>CC</sub> = Max, Except BI	V <sub>IN</sub> = 5.5V		4	400	μΑ
I <sub>IL</sub>	Logical "0" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V	Except BI		-300	-600	μΑ
		V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V		-1.2	-2.0	mA	
Icc	Power Supply Current	V <sub>CC</sub> = Max, R <sub>P</sub> = 2.2k, All	Inputs = 0V		27	43	mA
V <sub>CD</sub>	Input Diode Clamp Voltage	V <sub>CC</sub> = Max, T <sub>A</sub> = 25°C, I <sub>II</sub>	N = -12 mA		-0.9	-1.5	V
/Io	SEGMENT OUTPUTS		Outputs a, f, and g	0.84	0.93	1.02	
	"ON" Current Ratio	All Outputs = 50V,	Output c	1.12	1.25	1.38	
		I <sub>OUT</sub> b = Ref.	Output d	0.90	1.00	1.10	
			Output e	0.99	1.10	1.21	
I <sub>b ON</sub>	Output b "ON" Current	V - EV V - E- E0V	R <sub>P</sub> = 18.1k	0.15	0.20	0.25	mA
	-	$V_{CC} = 5V, V_{OUT}b = 50V,$	$R_P = 7.03k$	0.45	0.50	0.55	mA
		All Other Outputs ≥ 5V,	R <sub>P</sub> = 3.40k	0.90	1.00	1.10	mA
		T <sub>A</sub> = 25°C	R <sub>P</sub> = 2.20k	1.35	1.50	1.65	mA
V <sub>SAT</sub>	Output Saturation Voltage	V <sub>CC</sub> = Min, R <sub>P</sub> = 1k±5%, I	OUT b = 2 mA, (Note 5)		0.8	2.5	V
I <sub>CEX</sub>	Output Leakage Current	V <sub>OUT</sub> = 75V, BI = 0V, R <sub>P</sub>	= 2.2k		0.003	3	μΑ
V <sub>BR</sub>	Output Breakdown Voltage	I <sub>OUT</sub> = 250μA, BI = 0V, R	<sub>P</sub> = 2.2k	80	110		V
t <sub>pd</sub>	Propagation Delays						
	BCD Input to Segment Output			0.4	10	μs	
	BI to Segment Output	1 , 5, 7 , 5, 0		0.4	10	μς	
	RBI to Segment Output	$V_{CC} = 5V, T_A = 25^{\circ}C$		0.7	10	μς	
RBI to RBO					0.4	10	μs

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

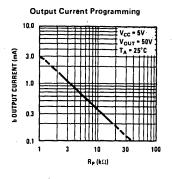
Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS7880 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS8880. All typical values are for  $T_{A} = 25^{\circ}$ C and  $V_{CC} = 5V$ .

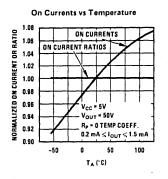
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

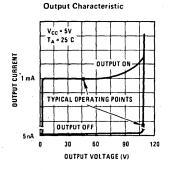
Note 4: In all applications transient segment output current must be limited to 50 mA. This may be accomplished in dc applications by connecting a 2.2k resistor from the anode supply filter capacitor to the display anode, or by current limiting the anode driver in multiplex applications.

Note 5: For saturation mode the segment output currents are externally limited and ratioed.

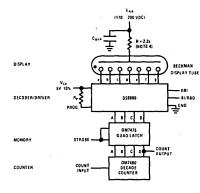
### **Typical Performance Characteristics**







## **Typical Application**



## **Truth Table**

DECIMAL OR FUNCTION	RBI <sup>†</sup>	D	С	В	А	BI/RBO	а	b	С	d	е	f	g	DISPLAY
0	1	0	0	0	0	1	0	0	0	0	0	0	1	$\Box$
1	×	0	0	0	1	1	1	0	0	1	1	1	1	_/
2	×	0	0	1	0	1	0	0	1	0	0	1	0	
3	×	0	0	1	1	1	0	0	0	0	1	1	0	
4	×	0	1	0	0	1	1	0	0	1	1	0	0	<i>-</i> /
5	×	0	1	0	1	1	0	1	0	0	1	0	0	<u> </u>
6	×	0	1	1	0	1	0	1	.0	0	0	0	0	15
7	×	0	1	1	1	1	0	0	0	1	1	1	1	7
8	×	1	0	0	0	1	0	0	0	0	0	0	Ô	⊟
9	x	1	0	0	1	1	0	0	0	0	1	0	0	5
10	×	1	0	1	0	1	0	0	0	1	0	0	0	/
11	×	1	0	1	1	1	1	1	0	С	0	0	0	· <i>1</i> =
12	×	1	1	0	0	1	0	1	1	0	0	0	1	
13	×	1	1	0	1	1	1	0	0	0 -	0	1	0	i≓
14	×	1	1	1	0	1	0	1	1	0	0	0	0	I I I
15	×	1	1	1	1	1	0	1	1	1	0	0	0	
BI*	×	×	×	×	х	0*	1	í	1	1	1	1	1	
RBI	0	0	0	0	0	0	1	1	1	1	1	1	1	

 $e \int_{-d}^{1} \int_{c}^{b} SEGMENT$   $e \int_{-d}^{d} \int_{c}^{c} IDENTIFICATION$ 

\*BI/RBO used as input only

<sup>†</sup>X = Don't care



## **Display Controllers/Drivers**

## **DS8881 Vacuum Fluorescent Display Driver**

#### **General Description**

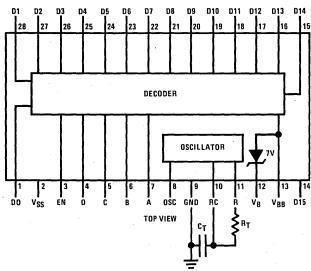
The DS8881 vacuum fluorescent display driver will drive 16-digit grids of a vacuum fluorescent display. The decode inputs select one of the sixteen outputs to be pulled high. The device contains an oscillator for supplying clock signals to the MOS circuit, the filament bias zener and 50  $k\Omega$  pull-down resistors for each grid. Outputs will source up to 7 mA. The DS8881 is designed for 9V operation. If the enable input is pulled low, all outputs are disabled.

#### **Features**

- Oscillator frequency accuracy and stability allows maximum system speed
- Interdigit blanking with the enable input provides ghost-free display operation
- 50 kΩ pull-down resistors for each grid
- 7V filament bias zener

#### **Connection Diagram**





Order Number DS8881N See NS Package N28A

Truth Table All outputs not shown high are off (low)

	11	VPUTS									D	IGIT O	UTPU	TS _						
EN	D	С	В	Α	0	1_	2	3	4	5	6	7	8	9	10	11	12	13	14	15
н	L	L	Ľ	L	Н															
Н	L	L	L	н		Н														
н	L	L	н	L			н													
н	L	·L	Н	н				н												
н	· L	н	L	L					Н											
н	\ L	н	L	H						н										
Η	i L	н	н	L							н									
н	L	Н	н	н								н								
н	Н	L	L	L									н							
H .	) н	L	L	н										Н						
н	Н	L.	н	L											н					
н	н	L	н	н	i											н				
н	Н	н	L	L										,			н			
Η	lн	н	L	Н :														Н		
н	н	н	н	L															H	
н	lн	н	н	н	l															1
L	×	×	X	X	lι	1.	1.	1.	L	L	L	L	L	L.	L.	L.	L	L	L	

<b>Absolute Maximum Ra</b>	tings (Note 1)	Operating Conditions							
•			MIN	MAX	UNITS				
Supply Voltage (VSS - VBB)	38V	Supply Voltage							
Input Current	10 mA	$V_{SS}$	5.0	9.5	V				
Output Current	−20 mA	V <sub>BB</sub>	· Gnd	-26	V				
Storage Temperature Range	-65° C to +150° C	Temperature (T <sub>A</sub> )	0	+70	°c				
Maximum Power Dissipation* at 25°C					-				
Molded Package	2168 mW								

300°C

#### Electrical Characteristics (Notes 2 and 3)

Lead Temperature (Soldering, 10 seconds) \*Derate molded package 17.35 mW/°C above 25°C.

	PARAMETER		CC	ONDITIONS		MIN	TYP	MAX	UNITS
VIH	Logical "1" Input Voltage	\/ M	Enable	I <sub>IN</sub> = 260 μA				5.1	· V
		Vss = Max	A, B, C, D	I <sub>IN</sub> = 1400 μA				1.5	V
ЧН	Logical "1" Input Current	V <sub>SS</sub> = Max	Enable A, B, (	C, D				260	μА
VIL	Logical "0" Input Voltage		Enable					1.0	V
		V <sub>SS</sub> = Max	A, B, C, D					0.3	V
IIL	Logical "0" Input Current	V <sub>SS</sub> = Max	Enable	VIN = 0V				-1.0	μΑ
		VSS - Wax	A, B, C, D	VIN = VIL(MAX	)	25			μΑ
Voн	Logical "1" Output Voltage	Digit Output	, I <sub>OH</sub> = -7 mA			V <sub>SS</sub> -2.5			V
ЮН	Logical "1" Output Current	V <sub>SS</sub> = Max, 0	10V			50	μΑ		
los	Output Short-Circuit Current	V <sub>SS</sub> = Min, P	in R, V <sub>RC</sub> = 0.6	6V, VR = 0V		-150		-450	μА
ROUT	Output Pull-Down Resistor	VSS = Min, D	igit Output			30	50	85	kΩ
VOL	Logical "0" Output Voltage	Vss = Min	Osc.	V=== 1 6V	IOL = 6 mA			0.5	V
		V 55 - WIII	Pin R	V <sub>RC</sub> = 1.6V	I <sub>OL</sub> = 60 μA			0.2	V
	· · · · · · · · · · · · · · · · · · ·	V <sub>SS</sub> = Max	Digit Output	VENABLE = 1V	I <sub>OL</sub> = 10 μA			V <sub>BB</sub> +1.4	V
Iss	Supply Current	V <sub>SS</sub> = 9.5V	I <sub>OH</sub> = 0	VENABLE = 5.1	V		9.0	12.5	mA
		VSS - 9.5V	IOH - U	VENABLE = 1V			5.0	9.0	mA
IBB	Supply Current	V <sub>SS</sub> = 9.5V,	I <sub>B</sub> = 0, I <sub>IN</sub> = 300 μA,	VENABLE = 1V	-		-0.8	-1.5	· mA
		, pp 204	(Note 4)	VENABLE = 5.1	V		-3.0	-5.0	mA
VB	Filament Bias Voltage	I <sub>B</sub> = 10 mA	I <sub>B</sub> = 10 mA				V <sub>BB</sub> +6.9	V <sub>BB</sub> +7.4	V

## Switching Characteristics TA = 25°C unless otherwise specified.

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd0</sub>	Propagation Delay to a Logical "0" From Enable Input to Digit Output				1	μs
t <sub>pd0</sub>	Propagation Delay to a Logical "0" A, B, C, D to Digit Output	0' 4740 0' 50 5 W 2004 W 204			1	μς
t <sub>pd1</sub>	Propagation Delay to a Logical "1" From Enable Input to Digit Output	$R'_{L} = 4.7 \text{ k}\Omega$ , $C'_{L} = 50 \text{ pF}$ , $V_{BB} = -23V$ , $V_{SS} = 8V$			300	ns
<sup>t</sup> pd1	Propagation Delay to a Logical "1" From A, B, C, D to Digit Output				500	ns
†FALL	Oscillator Output Transition Time From 1 to 0	V <sub>SS</sub> = 9.5V, R <sub>L</sub> = 6k to V <sub>SS</sub> , C <sub>L</sub> = 25 pF			50	ns
fosc	Oscillator Frequency	$7V < V_{SS} < 9.5V$ , $R_T = 27 \text{ k}\Omega, \pm 2\%$ , $R_L = 1.3\text{k}$ ,	320	360	400	kHz
dc	Oscillator Duty Cycle	C <sub>T</sub> = 100 pF ±5%, C <sub>L</sub> = 50 pF	46	56	66	%

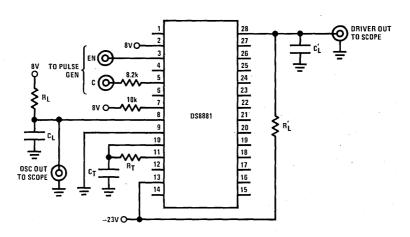
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C for the DS8881. All typicals are given for VCC = 5V and  $T_A = 25^{\circ}C$ .

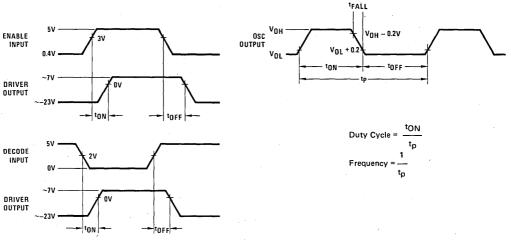
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

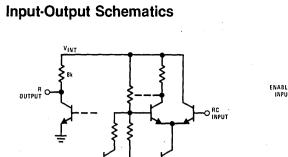
Note 4: Approximately 50% of input current on pins 4, 5, 6, 7 is shunted to VBB. If minimum IBB is desired, then IIN should be minimized by using resistors in series with the inputs.

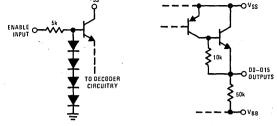
## **AC Test Circuit**

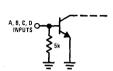


## **Switching Time Waveforms**



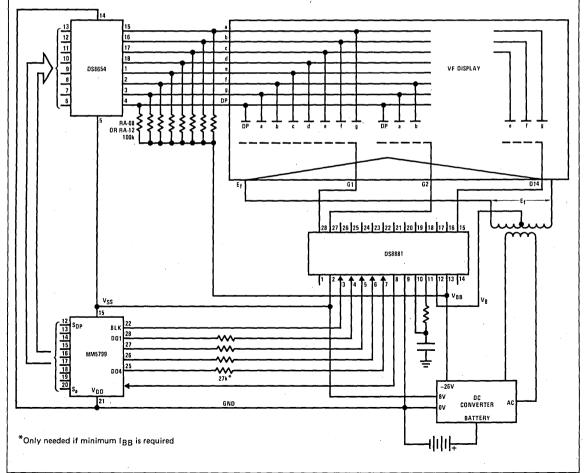








## **Typical Application**





## **Display Controllers/Drivers**

## **DS8884A High Voltage Cathode Decoder/Driver**

#### **General Description**

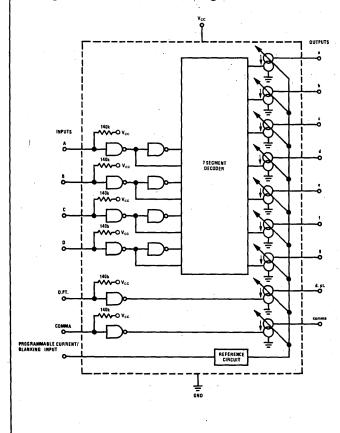
The DS8884A is designed to decode four lines of BCD input and drive seven-segment digits of gasfilled readout displays.

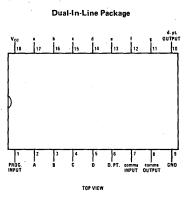
All outputs consist of switchable and programmable current sinks which provide constant current to the tube cathodes, even with high tube anode supply tolerance. Output currents may be varied over the 0.2 to 1.2 mA range for multiplex operation. The output current is adjusted by connecting an external program resistor ( $R_{\rm P}$ ) from  $V_{\rm CC}$  to the program input in accordance with the programming curve. Unused outputs must be tied to  $V_{\rm CC}$ .

#### **Features**

- Usable with AC or DC input coupling
- Current sink outputs
- High output breakdown voltage
- Low input load current
- Intended for multiplex operation.
- Input pullups increase noise immunity
- Comma/d.pt. drive

#### **Logic and Connection Diagrams**





Order Number DS8884AN See NS Package N18A

UNITS

#### Absolute Maximum Ratings (Note 1)

vcc		7V
Input Voltage (Note 4)		Vcc
Segment Output Voltage		80V
Power Dissipation		600 mW
Transient Segment Output Current (Note 5)	•	50 mA

Storage Temperature Range -65° C to +150° C Maximum Power Dissipation\* at 25° C

Molded Package

## Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITION	S	MIN	MAX	UNITS
V <sub>IH</sub>	Logical "1" Input Voltage	V <sub>CC</sub> = 4.75V		2.0		V
VIL	Logical "0" Input Voltage	V <sub>CC</sub> = 4.75V			1.0	٧
I <sub>IH</sub>	Logical "1" Input Current	V <sub>CC</sub> = 5.25V, V <sub>IN</sub> = 2.4V			15	μΑ
I <sub>IL</sub>	Logical "0" Input Current	V <sub>CC</sub> = 5.25V, V <sub>IN</sub> = 0.4V			-250	μΑ
I <sub>cc</sub>	Power Supply Current	V <sub>CC</sub> = 5.25V, R <sub>P</sub> = 2.8k, All	Inputs = 5V		40	mA
V <sub>1</sub> ,	Positive Input Clamp Voltage	V <sub>CC</sub> = 4.75V, I <sub>IN</sub> = 1 mA		5.0		V
V <sub>I-</sub>	Negative Input Clamp Voltage	$V_{CC} = 5V, I_{IN} = -12 \text{ mA}, T_{A}$		-1.5	V	
Δlo	SEGMENT OUTPUTS "ON" Current Ratio	All Outputs = 50V, I <sub>OUT</sub> b =	Ref., All Outputs	0.9	1.1	
I <sub>P ON</sub>	Output b "ON" Current	V <sub>CC</sub> = 5V, V <sub>OUT</sub> b = 50V, T <sub>A</sub> = 25°C	$R_{P} = 18.1k$ $R_{P} = 7.03k$ $R_{P} = 3.40k$ $R_{P} = 2.80k$	0.15 0.45 0.90 1.08	0.25 0.55 1.10 1.32	mA mA mA
I <sub>CE</sub> ×	Output Leakage Current	V <sub>OUT</sub> = 75V			5	μΑ
V <sub>BR</sub>	Output Breakdown Voltage	Ι <sub>ΟυΤ</sub> = 250μΑ		. 80		V
t <sub>pd</sub>	Propagation Delay of Any Input to Segment Output	V <sub>CC</sub> = 5V, T <sub>A</sub> = 25°C			10	μs

1714 mW

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C temperature range for the DS8884A. All typical values are for  $T_A = 25^{\circ}$ C and  $V_{CC} = 5$ V.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: This limit can be higher for a current limiting voltage source.

Note 5: In all applications transient segment output current must be limited to 50 mA. This may be accomplished in dc applications by connecting a 2.2k, resistor from the anode-supply filter capacitor to the display anode, or by current limiting the anode driver in multiplex applications.

#### **Truth Table**

FUNCTION	DPT.	COMMA	D	С	В	Α.	•	ь	c	d	•	f	9	DISPLAY
0	1	1	О	0	0	0	0	0	0	0	0	0	1	
1	,	١,	0	0	0	١,	1	0	0	1	1	,	1	1
2	- 1	1 1	0	0	1	0	0	o	1	0	0	1	0	2
3	1	- 1	0	0	1	1	0	0	0	0	1	1	0	7111
4	1	1 1	0	,	0	0	1	0	0	1	1	0	0	
5	1	1	0	1	0	١,	0	1	0	0	1	0	0	5
6	1 1	1	0	1	1	0	0	1	0	0	0	0	0	557
, ,	,	1	0	1.	1	1	0	0	0	1	1	1	١,	7
8	1	1	1	0	0	0	0	0	0	0	0	0	0	自
9	111	,	١,	0	0	ļ,	0	0	0	0	1	0	0	9
10	1 1	1	1	0	l ı	0	1	1	0	0	0	1	1	B
11	1 1	,	1 1	0	١,	,	1	1	e	0	0	١,	0	∄ -
12	1	.1	1	1	0	ò	١.	0	1	1	,	0	0	8
13	1	1 1	,	,	0	1	0	1	,	0	0	0	0	8
14	,	1	1	1	11:	0	١,	1	1	1	1	1	0	$\theta$
15	1	1	1	1	,	1	1	1	יו	1	١,	1	,	1
"D PT	0	1	×	×	×	×	×	×	×	×	×	×	١×	) :
*Comma	0	0	×	×	×	×	×	x	×	×	×	×	×	

# 1 / g / b e / d / c © Decimal Point p Comma

## **Typical Application**

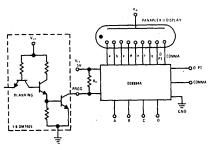
**Operating Conditions** 

4.75

5.25 +70

Supply Voltage (V<sub>CC</sub>)

Temperature (TA)



## Typical Performance Characteristics (see DS7880 data sheet)

<sup>\*</sup>Derate molded package 13.71 mW/°C above 25°C.

<sup>\*</sup>Decimal point and comma can be displayed with or without any numeral.



## **Display Controllers/Drivers**

## **DS8885 MOS to High Voltage Cathode Buffer**

#### **General Description**

The DS8885 interfaces MOS calculator or counterlatch-decoder-driver circuits directly to 7-segment, high-voltage, gas-filled displays. The six inputs A, B, D, E, F, G are decoded to drive the 7-segment of the tube.

Each output constitutes a switchable, adjustable current source which provides constant current to the tube segment, even with high tube anode supply tolerance or fluctuation. These current sources have a voltage compliance from 3V to at least 80V. Each current source is ratioed to the b-output current as required for even illumination of all segments. Output currents may be varied over the 0.2 to 1.5 mA range for driving various tube types or

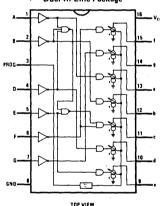
multiplex operation. The output current is adjusted by connecting a program resistor ( $R_P$ ) from  $V_{CC}$  to the program input.

#### **Features**

- Current source outputs
- Adjustable output currents 0.2 to 1.5 mA
- High output breakdown voltage 80V min
- Suitable for multiplex operation
- Low fan-in and low power
- Blanking via program input
- Also drives overrange, polarity, decimal point cathodes

#### Connection Diagram

#### Dual-In-Line Package



Order Number DS8885J or DS8885N See NS Package J16A or N16A

## **Truth Tables**

	Α	В	D	E	F	G	DISPLAY
	1	1	1	1	1	0	
	0	1	0	0	0	0	1
	1	1	1	1	0	1	[
1	1	1	1	0	0	1	3
-	0	1	0	0	1	1	4
	1	0	1	0	1	1	机型头板 医多数的现在分词
	1	0	1	1	1	1	5
	1	1	0	0	0	0	7
	1	1	1	1	1	1	B
	1	1	1	0	1	1	9
	0	0	1	1	1	1	<i>5</i>
	1	1	0	0	1	1	4
	1	1	0	1	1	1	17
	0	1	0	1	1	1	1-1
	0	1	1	1	1	0	· <i>LI</i>
	0	0	0	0	0	1	
	0	0	0	0	0	0	

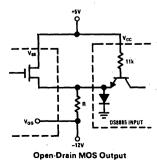
INPUT*	оитрит•
0	1 (OFF)
1	0 (ON)

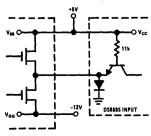
<sup>&#</sup>x27;Positive Logic



C = (A-R-D + E)

## **Typical Applications**





**Push-Pull MOS Output** 

## 5

#### Absolute Maximum Ratings (Note 1)

Vcc	7V
Input Voltage	6V
Segment Output Voltage	80V
Power Dissipation	600 mW
Transient Segment Output Current (Note 4)	50 mA

Storage Temperature Range -65° C to +150° C

Maximum Power Dissipation\* at 25° C

Cavity Package 1509 mW

Molded Package .
Lead Temperature (Soldering, 10 seconds)

\*Derate cavity package 10.06 mW/° C above 25° C; derate molded package 11.81 mW/° C above 25° C.

## Electrical Characteristics (Notes 2 and 3)

	PARAMETER		CONDITI	ONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	Logical "1" Input Voltage	V <sub>CC</sub> ≈ Min			2.0			V
V <sub>IL</sub>	Logical "O" Input Voltage	V <sub>CC</sub> = Min					0.8	<b>V</b>
LiH	Logical "1" Input Current	V <sub>CC</sub> = Max	V <sub>IN</sub> = 2.4	V		2	15	μΑ
		V CC - IVIAX	V <sub>IN</sub> = 5.5	V		4	400	μΑ
I <sub>IL</sub>	Logical "0" Input Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.4V			-300	-600	μΑ	
lcc	Power Supply Current	V <sub>CC</sub> = Max, All Inputs = 0V, R <sub>P</sub> = 2.2k			22	31	mA	
V <sub>I</sub>	Input Diode Clamp Voltage	$V_{CC} = 5V, I_{IN} = -12 \text{ mA}, T_A = 25^{\circ}\text{C}$			-0.9	-1.5	, V	
SEGM	ENT OUTPUTS			· · · · · · · · · · · · · · · · · · ·		1		
10	"ON" Current Ratio		,Out	puts a, f, and g	0.84	0.93	1.02	
	,	All Outputs = 50	Il Outputs = 50V, Output c		1.12	1.25	1.38	
		I <sub>OUT</sub> b = Ref.	Out	put d	0.90	1.00	1.10	
			Out	put e	0.99	1.10	1.21	
I <sub>b ON</sub>	Output b "ON" Current			R <sub>P</sub> ≈ 18.1k	0.15	0.20	0.25	mA
	·	V <sub>cc</sub> = 5V, V <sub>ου</sub> -	<sub>r</sub> b = 50V,	$R_P = 7.03k$	0.45	0.50	0.55	mA
		$T_A = 25^{\circ}C$		$R_P = 3.40k$	0.90	1.00	1.10	mA
				$R_P = 2.20k$	1.35	1.50	1.65	mA
V <sub>SAT</sub>	Output Saturation Voltage	V <sub>CC</sub> = Min, I <sub>OU</sub>	<sub>r</sub> b = 2 mA,	R <sub>P</sub> = 1k ±5%, (Note 5)		0.8	2.5	٧
I <sub>CEX</sub>	Output Leakage Current	V <sub>OUT</sub> = 75V, V	<sub>N</sub> = 0.8V, R	<sub>P</sub> = 1k		0.003	3	μΑ
V <sub>BR</sub>	Output Breakdown Voltage	Ι <sub>ΟυΤ</sub> = 250μΑ,	V <sub>IN</sub> = 0.8V		80	110		<b>&gt;</b>
t <sub>pd</sub>	Propagation Delay of Input to Segment Output	V <sub>CC</sub> = 5V, T <sub>A</sub> =	25°C			0.4	10	μς

1476 mW 300° C **Operating Conditions** 

Supply Voltage (VCC)

Temperature (T<sub>A</sub>)

MIN

4.75

0

MAX

5.25

+70

UNITS

ν

°c

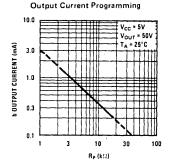
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

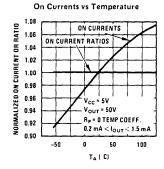
Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range for the DS8885. All typical values are for  $T_A = 25^{\circ}C$  and  $V_{CC} = 5V$ .

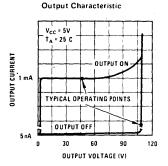
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: In all applications transient segment output current must be limited to 50 mA. This may be accomplished in dc applications by connecting a 2.2k resistor from the anode-supply filter capacitor to the display anode, or by current limiting the anode drive in multiplex applications. Note 5: For saturation mode the segment output currents are externally limited and ratioed.

#### **Typical Performance Characteristics**







# National Semiconductor

## **Display Controllers/Drivers**

DS8887 8-Digit High Voltage Anode Driver (Active-High Inputs)
DS7889/DS8889 8-Segment High Voltage Cathode Driver (Active-High Inputs)
DS7897A/DS8897A 8-Digit High Voltage Anode Driver (Active-Low Inputs)
General Description

The DS8887 and DS7897A/DS8897A are designed to drive the individual anodes of a 7-segment (cathodes) high-voltage gas discharge panel in a time multiplexed fashion.

When driven with appropriate input signals, the driver will switch voltage and impedance levels at the anode. This will allow or prevent ionization of gas around selected cathode in order to form a numeric display. This main application is to interface with MOS outputs (fully-decoded) and the anodes of a gas-discharge panel, since the devices can source up to 16 mA at a low impedance and can tolerate more than 55V in the "OFF" state.

DS7889/DS8889 is capable of driving 8 segments of a high-voltage display tube with a constant

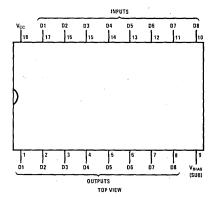
output sink current, which can be adjusted by external program resistor,  $R_{\rm P}.$  The program current is half that of output "ON" current. In the "OFF" state the outputs can tolerate more than 80V. The ratio of "ON" output currents is within  $\pm 10\%.$  Inputs have negative clamp diodes. Active high input logic. The main application of the device is to interface MOS circuits to high-voltage displays. Unused outputs should have corresponding inputs connected to  $V_{\rm FE}$ .

#### **Features**

- Versatile circuits for a wide range of display applications
- High breakdown voltages
- Low power dissipation

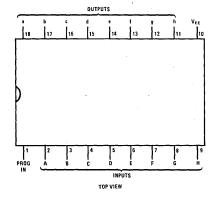
#### Connection Diagrams (dual-in-line packages)

#### DS8887, DS7897/DS8897



Order Number DS7897AJ, DS8887J, DS8897AJ or DS8897AN See NS Package J18A or N18A

#### DS7889/DS8889



Order Number DS7889J, DS8889J or DS8889N See NS Package J18A or N18A

Supply Voltage (V <sub>CC</sub> - V <sub>BIAS</sub> ) (Note 2) DS8887, DS7897A, DS8897A -60V	Operating Condition	115			
			MIN	MAX	UNITS
Supply Voltage (VCC - VBIAS) (Note 2)		Supply Voltage (VCC - BBIAS)			
DS8887, DS7897A, DS8897A	-60V	DS8887, DS7897A/DS8897A	-40	<del></del> 60	V
Input Voltage		Temperature (T <sub>A</sub> )			
DS8887, DS7897A/DS8897A	-20V	DS7889, DS7897A	55	+125	°C
DS7899/DS8889 (Note 3)	35V	DS8897' DS8889, DS8897A	0	+70	°c
Output Voltage	4				
DS8887, DS7897A/DS8897A	-65V				
DS7889/DS8889	85V				
Storage Temperature Range	–65° C to +150° C				
DS7889/DS8889 Maximum Power Dissipation	n <sup>*</sup> at 25°C				
Cavity Package	1436 mW				
Molded Package	1563 mW				
DS8887, DS7897A/DS8897A Maximum Pow	er Dissipation <sup>†</sup> at				
25°C		*Derate cavity package 11.49 mW/	°C above	25°C; dera	te molded
Cavity Package	1496 mW	package 12.5 mW/°C above 25°C			
Molded Package	1714 mW	†Derate cavity package 11.97 mW/	°C above	25°C; dera	te molded
Lead Temperature (Soldering, 10 seconds)	300°C	package 13.71 mW/°C above 25°	C.	* '	

## Electrical Characteristics (Notes 2, 3 and 4)

	PARAMETER		CONDITIONS		MIN	TYP	MAX	UNIT
	3897A, DS7897A						,	
V <sub>IH</sub>	Logical "1" Input Voltage	V <sub>OUT</sub> = -1.4V, I <sub>C</sub>	-2.0					
VIL	Logical "0" Input Voltage	$V_{OUT} = -60V, I_{O}$	UT = -100μA, D	S8887			-5.5	
I <sub>IH</sub>	Logical "1" Input Current	V <sub>OUT</sub> = -1.4V, I <sub>C</sub>	out = -16 mA, D	S8897A, DS7897A	-300			μΑ
t <sub>IL</sub>	Logical "0" Input Current	V <sub>OUT</sub> = -60V, I <sub>O</sub>			-10	μΑ		
l <sub>t</sub>	Input Current	V <sub>IN</sub> = -1.0V				335	550	μΑ
			= -6.0V			0.2	−25	μA
		V <sub>IN</sub>	= -12V		-0.10		-0.65	m/
		DS7897A, DS889	7A, V <sub>IN</sub> = -12V		-0.45		-1.5	m/
V <sub>OUT OFF</sub>	Output "OFF" Voltage	I <sub>OUT</sub> = -100μA, I	<sub>IN</sub> = 0μA		-60	-77		
OUT OFF	Output "OFF" Current	V <sub>OUT</sub> ≈ -55V, I <sub>IN</sub>	η = 0μΑ			-0.03	-5.0	μ
V <sub>OUT ON</sub>	Output "ON" Voltage	16 - A		-1.0	-1.4			
		10UT16 IIIA	$I_{1N} = -300\mu A,$	DS8887 DS8897A, DS7897A			-1.4	
IBIAS	V <sub>BIAS</sub> Current		$I_{OUT} = -16 \text{ mA},$ $V_{IN} = -1.0V, DS8887, (Note 5)$			-2.2	-4.0	m
			$I_{1N} = -300\mu A$ ,	DS8897A, DS7897A			-1.0	m.
	}	VBIAS OUV	V <sub>BIAS</sub> = -60V (One Driver Only)				""	••••
DS7889/DS8	3889		<del></del>					
I <sub>t</sub>	Input Current	V <sub>IN</sub> = 6.0V	٠.	· .	150	250	350	μ
1,_	Logical "0" Input Current	$I_{OUT} = 5.0 \mu A, V_{C}$	<sub>DUT</sub> = 75V				7.0	μ
I <sub>IH</sub>	Logical "1" Input Current	I <sub>OUT</sub> = 1.4 mA, I	<sub>IP</sub> = 850μA, V <sub>O</sub> ι	τ = 50V	80			·μ
V <sub>1</sub>	Input Clamp Voltage	I <sub>IN</sub> = -1.0 mA, T,	<sub>A</sub> = 25°C	1. 14		-0.68	-0.85	
V <sub>он</sub>	Output Breakdown Voltage	Ι <sub>ΟυΤ</sub> = 100μΑ, Ι <sub>Ι</sub>	<sub>N</sub> = 0μA		80			
CEX	Output Leakage Current	V <sub>OUT</sub> = 75V, −0.	$1 \text{ mA} \le I_{IN} \le 7$	0μΑ		0.02	5.0	μ
PROG	Prog. Input Voltage	I <sub>IP</sub> = 150μΑ			1.8	2.3		,
		I <sub>IP</sub> = 850μA				4.0	4.5	
loL	Logical "0" Output Current		1 - 150	DS7889	210	300	390	μ
			I <sub>IP</sub> = 150μA	DS8889	240	300	360	μ
		V <sub>OUT</sub> = 50V,	I <sub>IP</sub> = 400μA	DS7889	660	800	940	μ
		$80\mu A \leq I_{1N} \leq I_{1P}$	1 ip = 400µA	DS8889	680	800	920	μ
		$I_{1R} = 850 \mu A$		DS7889	1.45	1.7	1.95	m.
		·	110 00000	DS8889	1.53	1.7	1.87	m
	Output Current Ratio	I <sub>OUT</sub> b Ref = 1.7 mA, V <sub>OUT</sub> = 50V			0.9	1.0	1.1	

## Switching Characteristics $T_A = 25^{\circ}C$ unless otherwise specified.

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
D\$888	7				,	
t <sub>ON</sub>	Propagation Delay from Input to Output:"ON"	(See ac Test Circuit and Switching Time Waveforms)			5.0	μs
t <sub>RISE</sub>	Propagation Delay from Input to Output "ON"	(See ac Test Circuit and Switching Time Waveforms)			1.0	μs
DS788	9/DS8889					
t <sub>pd0</sub>	Propagation Delay to a Logical "O" from Input to Output	R <sub>P</sub> = 6.0k to 6.0V, R <sub>OUT</sub> = 1.0k to 6.0V		37	100	ns
t <sub>pd1</sub>	Propagation Delay to a Logical "1" from Input to Output	Input Ramp Rate $\leq$ 15 ns, Freq = 1.0 MHz dc = 50%, Amplitude = 6.0V		92	200	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

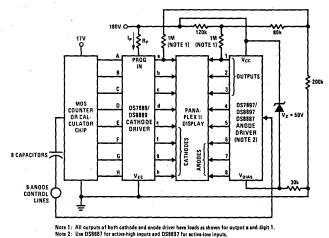
Note 2: All voltage shown for DS8887, DS7897A/DS8897A W.R.T. V<sub>CC</sub> = 0V. All currents into device pins shown as positive, out of device pins as negative. All values shown as max or min on absolute basis.

Note 3: All voltages for DS7889/DS8889 with respect to  $V_{EE} = 0V$ .

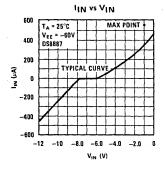
Note 4: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DS7889 and DS7897A, and across the 0°C to +70°C range for the DS8887, DS8889 and DS8897A. All typicals are given for TA = 25°C.

Note 5: Supply currents specified for any one input = -1.0V. All other inputs = -5.5V and selected output having 16 mA load.

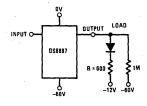
## **Typical Application**

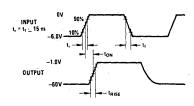


## Typical Performance Characteristics

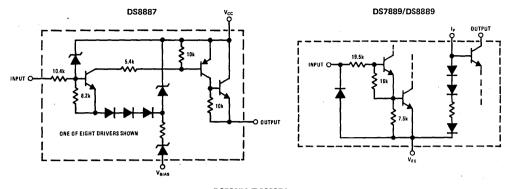


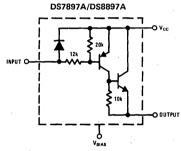
## **AC Test Circuit and Switching Time Waveforms**





## **Logic Diagrams**





## **Display Controllers/Drivers**

# **DS8891A High Voltage Anode Drivers** (Active-Low Inputs)

#### **General Description**

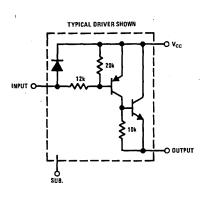
The DS8891A is a 6 digit anode driver intended for use with seven segment, common anode, high voltage, gas discharge display panels operating in a multiplexed mode. The driver switches voltage and impedance levels at the display's anode allowing or preventing ionization of gas around selected cathodes, forming a numeric display. The device acts as a buffer between MOS outputs (fully decoded) and the anodes of a gas-discharge panel,

and it can source up to 16 mA at a low impedance and can withstand more than 55V in the off state.

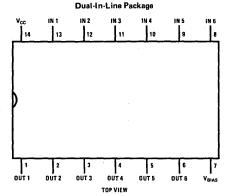
#### **Features**

- High breakdown voltage
- Low power dissipation
- Easy interface to clock and calculator circuits

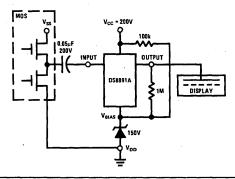
#### **Schematic and Connection Diagrams**



## **Typical Application**



Order Number DS8891AJ or DS8891AN See NS Package J14A or N14A



## Absolute Maximum Ratings (Note 1)

Supply Voltage (VCC - VBIAS)	-60V
Input Voltage	-20V
Output Voltage	-65V
Storage Temperature Range	-65° C to +150° C

Maximum Power Dissipation\* at 25° C Cavity Package 1433 mW 1398 mW Molded Package 300°C Lead Temperature (Soldering, 10 seconds)

\*Derate cavity package 9.55 mW/°C above 25°C; derate molded package 11.18 mW/°C above 25°C.

## **Operating Conditions**

	MIN	MAX	UNITS
Supply Voltage, VCC - VBIAS	<b>-4</b> 5	<b>-55</b>	V
Temperature, TA	0	+70	°C

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
I <sub>IN</sub> Input Current		V <sub>BIAS</sub> = Min, V <sub>IN</sub> = -12V	-0.6		-1.5	mA
I <sub>IH</sub>	Logical "1" Input Current	V <sub>BIAS</sub> = Min, V <sub>OL</sub> = -2.0V	-300			μΑ
IIL	Logical "0" Input Current	$V_{BIAS} = Min, V_{OUT} = -60V, I_{OUT} = -100\mu A$			-10	μΑ
I <sub>OH</sub>	Logical "1" Output Current	$V_{BIAS} = Max$ , $I_{IN} = 0\mu A$ , $V_{OH} = -55V$			-5	μΑ
VoL	Logical "0" Output Voltage	$I_{OL} = -16 \text{ mA}, \ I_{IH} = -300 \mu\text{A}$			-2.0	V
V <sub>BD</sub>	Output Breakdown Voltage	$V_{BIAS} = Max$ , $I_{IN} = 0\mu A$ , $I_{OUT} = -100\mu A$	-60			٧
IBIAS	Supply Current (Substrate)	$V_{BIAS} = Max$ , $I_{IH} = -300\mu A$ , $I_{OL} = -16 \text{ mA}$ , (One Driver Only)			-1.0	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range for the DS8891A.

Note 3. All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to  $V_{CC}$  = 0V, unless otherwise noted. All values shown as max or min on absolute value basis.



## **Display Controllers/Drivers**

## DS8973, DS8975 9-Digit LED Drivers

#### **General Description**

The DS8973 is a 9-digit driver designed to operate from 3-cell battery supplies. Each driver will sink 100 mA to less than 0.7V when driven by only 0.1 mA. Each input is blocked by diodes so that the input can be driven below ground with virtually no current drain. This is especially important in calculator systems employing a dc-to-dc converter on the negative side of the battery. If the converter were on the positive side of the battery, the converter would have to handle all of the display current, as well as the MOS calculator chip current. But if it is on the negative side, it only

has to handle the MOS current. The DS8973 is designed for the more efficient operating mode. The DS8975 is identical to the DS8973 but does not specify the low battery indicator.

#### **Features**

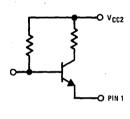
- Nine complete digit drivers
- Built-in low battery indicator
- High current outputs-100 mA
- Straight through pin out for easy board layout

## **Equivalent Circuit Diagrams**

Typical Driver Circuit

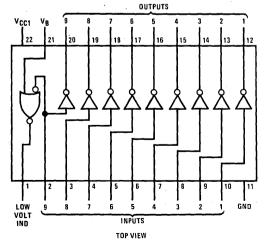
INPUT O DUTPUT

Typical D.P. Out Circuit



#### **Connection Diagrams**

**Dual-In-Line Package** 



Order Number DS8973N or DS8975N See NS Package N22A

## **Absolute Maximum Ratings** (Note 1)

## **Operating Conditions**

			MIN	MAX	UNITS
Supply Voltage	10V	Supply Voltage (Vg)	3,0	5.5	V
Input Voltage	10V	Supply Voltage (VCC1)	3.0	9.5	V
Output Voltage	10V	Temperature (T <sub>A</sub> )	0	+70	°c
Storage Temperature Range	-65°C to +150°C		-		-
Maximum Power Dissipation at 25°C					
Molded Package	1672 mM				

300°C

Lead Temperature (Soldering, 10 seconds)

#### **Electrical Characteristics**

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
VIH	Logical "1" Input Voltage	VCC = Max		3.9			V
l <sub>IH</sub>	Logical "1" Input Current	VCC = Max, V <sub>IH</sub> = 3.9V		0.1		0.3	mA
VIL	Logical "0" Input Voltage	VCC = Max				0.5	V
HL	Logical "0" Input Current	VCC = Max, VIL = 0.5V				40	μΑ
Vвн	High Battery Threshold	$V_{OT}$ (Pin 1) = 1V, $I_{OT} \le -50\mu$ A, $T_A = 25^{\circ}$ C, $V_{IH}$ (Pin 2) = 3.9V	DS8973	3.6			٧
VBL	Low Battery Threshold	$V_{OT}$ (Pin 1) = 2.1V, $I_{OT} \ge -6$ mA, $T_A = 25^{\circ}$ C, $V_{IH}$ (Pin 2) = 3.9V	DS8973			3.2	٧
ICEX	Logical "1" Output Current	VCC = Min, VOH = 9.5V, VIL = 0.5V				50	μΑ
VOL	Logical "0" Output Voltage	VCC = Min, IOL = 100 mA, VIH = 3.9V				0.7	V
ICC1	Supply Current	VCC = Max, One Input "ON"				6	mA
I <sub>B</sub>	Pin 21 (High Battery Supply)	VCC = Max, VB = Max				1.2	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the  $0^{\circ}$ C to +70° C range. All typicals are given for  $T_A = 25^{\circ}$ C. Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

<sup>\*</sup>Derate molded package 13.39 mW/°C above 25°C.

## Typical Applications

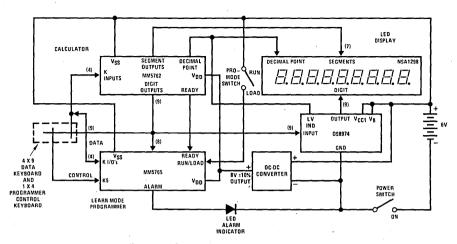


FIGURE 1. 6V Programmable Statistical Calculator

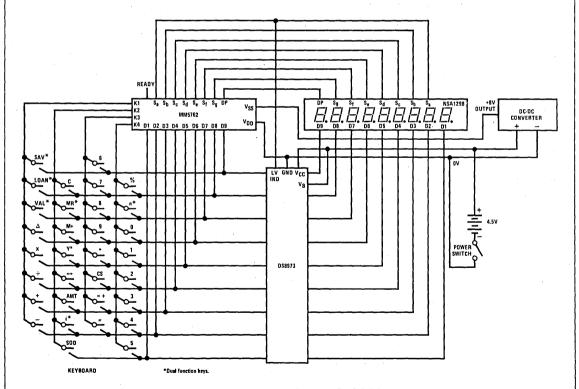


FIGURE 2. Complete Calculator Schematic For 3-Cell System

## 5

## Driving 7-Segment Gas Discharge Display Tubes with National Semiconductor Circuits



#### INTRODUCTION

Circuitry for driving high voltage cold cathode gas discharge 7-segment displays, such as Sperry Information Displays\* and Burroughs Panaplex II, is greatly simplified by a complete line of monolithic integrated circuits from National Semiconductor. These products also make possible reduced cost of system implementation. They are: DS8880 high voltage cathode decoder/driver; DS8884A high voltage cathode decoder/driver; DS8885 MOS to high voltage cathode buffer; DS8889 low power cathode driver; DS8887 8-digit anode driver; DS8980, DS8981 latch/decoder/cathode drivers.

In addition to satisfying all the displays' parameter requirements, including high output breakdown voltage, these circuits have capability of programming segment current, and providing constant current sinking for the display segments. This feature alleviates the problem of achieving uniformity of brightness with unregulated display anode voltage. The National circuits can drive the displays directly.

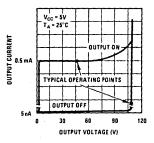
Sperry Information Displays\* and Burroughs Panaplex II are used principally in calculators and digital instruments. These 7-segment, multi-digit displays form characters by passing controlled currents through the appropriate anode/segment combinations. The cathode in any digit will glow when a voltage greater than the ionization voltage is applied between it (the cathode) and the anode for that digit. In the multiplexed mode of operation, a digit position is selected by driving the anode for that digit with a positive voltage pulse. At the same time, the selected cathode segments are driven with a negative current pulse. This causes the potential between the anode and the selected cathodes to exceed the ionization level, causing a visible glow discharge.

Generally, these displays exhibit the following characteristics: low "on" current per segment-from  $200\mu A$  (in DC mode) to 1.2 mA (in multiplex mode); high tube anode supply voltage–180V to 200V; and moderate ionization voltage–170V. Once the element fires, operating voltage drops to approximately 150V and light output becomes a direct function of current, which is controlled by current limiting or current regulating cathode circuits. Current regulation therefore is most desirable since brightness will then be constant for large anode voltage changes. Tube anode to cathode "off" voltage is approximately 100V; and maximum "off" cathode leakage is  $3\mu A$  to  $5\mu A$ .

Correspondingly, specifications for the cathode driver must be complimentary, approximately as follows: A high "off" output breakdown voltage 80V; minimum; typical "on" output voltage of 50V; maximum "on" output current of 1.5 mA per segment; and maximum "off" leakage current of 3µA to 5µA.

To allow operation without anode voltage regulation, the cathode driver must be able to sink a constant current in each output, with the output

#### (a) Cathode Driver Output Characteristic



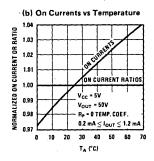


FIGURE 1.

"on" voltage ranging from 5V to 50V (see Figure 1). The following is a brief description of the circuits now offered by National:

#### DS8880 High Voltage Cathode Decoder/Driver

The DS880 offers 7-segment outputs with high output breakdown voltage of 80V minimum; constant current-sink outputs; and programmable output current from 0.2 mA to 1.5 mA.

<sup>\*</sup>Now called Beckman Displays

#### Application

The circuit has a built-in BCD decoder and can interface directly to Sperry and Panaplex II displays, minimizing external components (Figure 2). The inputs can be driven by TTL or MOS outputs directly. It is optimized for use in systems with 5V supplies.

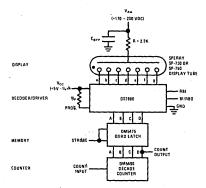


FIGURE 2. DC Operation From TTL

The DS8880 decoder/driver provides for unconditional as well as leading and trailing zero blanking. It utilizes negative input voltage clamp diodes. Typically, output current varies only 1% for output voltage changes of 3V to 50V. Operating power supply voltage is 5V. The device can be used for multiplexed or DC operation.

Available in 16-pin cavity DIP packages, the DS7880 is guaranteed over the full military operating temperature range of  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ; the DS8880 in molded DIP over the industrial range of  $0^{\circ}\text{C}$  to  $+70^{\circ}\text{C}$ .

#### DS8980, DS8981

The DS8980, DS8981 offer 7-segment and decimal point outputs with high output breakdown voltage of 80V minimum, constant current, programmable from 0.1 mA to 4.0 mA and independent of the VCC voltage, latched BCD inputs and decimal point input.

#### Application

The circuits have similar applications as DS8880. The devices will operate with a power supply

range of from 4.75V to 15.0V. The input fall-through latches are enabled by a high logic level at the enable input for the DS8980, and by a low logic level for the DS8981.

Available in 18-pin molded dual-in-line packages, and guaranteed over the commercial range of  $0^{\circ}$ C to  $+70^{\circ}$ C.

#### DS8884A High Voltage Cathode Decoder/Driver

The DS8884A offers 9-segment outputs with high output breakdown voltage of 80V minimum; constant current-sink outputs, programmable from 0.2 mA to 1.2 mA. It also offers input negative and positive voltage clamp diodes for DC restoring, and low input load current of -0.25 mA maximum.

#### Application

DS8884A decodes four lines of BCD input and drives 7-segment digits of gas-filled displays. There are two separate inputs and two additional outputs for direct control of decimal point and comma cathodes. The inputs can be DC coupled to TTL (Figure 3) or MOS outputs (Figure 4), or AC-coupled to TTL or MOS outputs (Figure 5) using only a capacitor. This means the device is useful in applications where level shifting is required. It can be used in multiplexed operation, and is available in an 18-pin molded DIP package.

Other advantages of the DS8884A are: typical output current variation of 1% for output voltage changes of 3V to 50V; and operating power supply

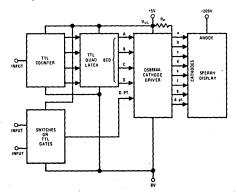


FIGURE 3. Interfacing Directly With TTL Output

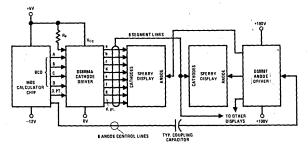
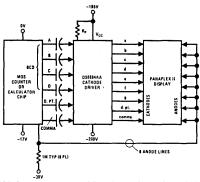


FIGURE 4. BCD Data Interfacing Directly With MOS Output





NOTE: Capacitive coupling between the logic and the segment drivers may be used only when the segment drivers are turned "OFF" during digit-to-digit transitions.

FIGURE 5. Cathode BCD Data AC Coupled From MOS Output

voltage of 5V. Inputs have pull-up resistors to increase noise immunity in AC coupled applications.

The DS8884A is guaranteed over the 0°C to +70°C operating temperature range.

#### DS8885 MOS to High Voltage Cathode Buffer

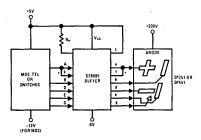
The DS8885 features seven constant current-sink outputs; programmable output current of 0.2 mA to 1.5 mA; high output breakdown voltage of 80V minimum; and capability for blanking through program current input. It operates from a +5V supply.

#### Application

DS8885 is best suited for interfacing 7-segment fully decoded MOS chips to digit displays. It is also useful for driving polarity, overrange, and decimal point segments.

DS8885 has 6 inputs and 7 outputs. Output c is decoded internally; the other 6 outputs are directly controlled by the 6 corresponding inputs. A typical application of this device is interfacing between an MOS calculator chip with 7-segment decoded outputs (open-drain or push-pull) and Sperry/Panaplex II displays (Figure 6).

When the DS8885 is used to drive minus and plus (polarity) cathodes, overrange, and decimal points, output c should be tied to  $V_{CC}$  so it does not saturate (Figure 7). This leaves 6 inputs and 6 outputs related one-to-one. The inputs can be driven directly from TTL or MOS outputs.



\*Output may be paralleled for cathodes requiring more current, providing the corresponding inputs are also paralleled.

FIGURE 7. Polarity, Overrange, Decimal Point Driving

The DS8885 is available in 16-pin molded DIP package, and is guaranteed over the operating temperature range of  $0^{\circ}$ C to  $+70^{\circ}$ C.

#### DS8889 Low Power Cathode Driver

The DS8889 requires no power supply since power is derived from program current. It offers extremely low standby power—only 1 mW internally. Features include programmable output currents 0.3 mA to 1.7 mA; 8 constant current-sink outputs; and input negative voltage clamp diodes for DC restoring. Outputs have 80V minimum breakdown voltage.

The device is suitable for multiplexed operation from fully decoded chips and is capable of driving decimal point segments simultaneously with numeric segments.

#### Application

The DS8889 has 8 inputs and 8 outputs, and interfaces directly between 7-segment decoded MOS outputs and numeric display tubes (Figures 8 and 9). It is optimized for use in systems with a limited number of power supplies.

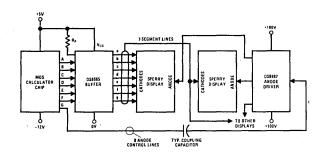


FIGURE 6. Fully Decoded MOS Cathode Outputs

The program input is characterized in terms of input current, therefore any supply (greater than 5V) can provide proper operation by connecting a single resistor to the program pin from the supply.

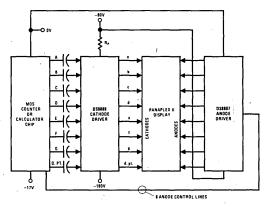
The DS889, guaranteed for the 0°C to +70°C operating temperature range, is offered in the 18-pin molded DIP.

#### DS8887 8-Digit Anode Driver

The DS8887 interfaces directly to MOS chips and operates from a -40V to -80V power supply.

The DS8887 can operate virtually any multiplex display system requiring more output performance from the MOS chip than is available (Figures 4, 6, 8 and 9). It has low input current and voltage swing requirements but can drive up to 16 mA, and exhibits -55V minimum output breakdown voltage.

The DS8887 is available in the 18-pin molded DIP package; and is guaranteed over the operating temperature range of  $0^{\circ}$ C to  $+70^{\circ}$ C.



NOTE: Capacitive coupling between the logic and the segment drivers may be used only when the segment drivers are turned "OFF" during digit-to-digit transitions.

FIGURE 8. Decoded Cathode Data AC Coupled From MOS Output

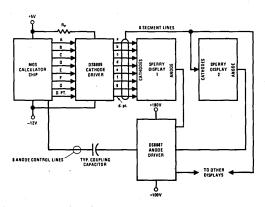


FIGURE 9. Decoded Cathode Data Direct Coupled From MOS Output

## Driving 7-Segment LED Displays with National Semiconductor Circuits

National Semiconductor Application Note 99 Charles Carinalli May 1974



#### INTRODUCTION

There are many different information display technologies available today, including liquid crystals, gas-discharge tubes, fluorescent tubes, incandescent lamps, and light emitting diodes (LEDs). Each technology has its own particular drive requirement. This note will focus on 7-segment LED display drive requirements and demonstrate that National Semiconductor has a full line of display drivers that meet the requirements for most any 7-segment LED drive application.

#### WHY ARE LED DRIVERS NEEDED?

The purpose of 7-segment LED drivers is to act as an interface element between data input and the display. This interface is necessary when either the input data format or circuitry current capabilities do not allow direct connection between input and display. To satisfy these needs, National's 7-segment LED drivers are divided into two basic categories.

1. Internally decoded (BCD to 7-segment)
DM5446A/DM7446A
DM5447A/DM7447A
DM5448/DM7448
DM7856/DM8856
DM8857
DM7858/DM8858

2. Non-decoding, direct drive (MOS to 7-segment)

DM75491 DM75492 DM8864 DM8865

DM8861

DM8866

DM8863

non-decoded outputs.

Thus, National has circuits that will drive 7-segment LEDs from either fully decoded circuits or from

CONFIGURATIONS AND CONSTRUCTION OF 7-SEGMENT LEDS

LEDs are segregated into two groupings with regard to construction, see Figure 1.

Common anode displays are constructed on a common substrate which forms the anode of the diodes, while each of the seven cathodes are bonded out to separate pins. The second type, common cathode, has the cathode fabricated on a common substrate with the anodes bonded out to individual pins. Due to these radically different configurations, drive circuits are usually tailored in their design for one or the other type. Tailoring in this respect means either sinking current (active low) or sourcing current (active high) when referenced to segment drive. In addition, drive requirements are quite variable because of LED light intensity requirements as well as digit size

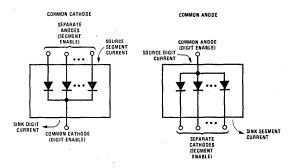


FIGURE 1. 7-Segment LED Construction



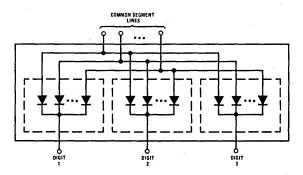


FIGURE 2. Multi-Digit 7-Segment LED

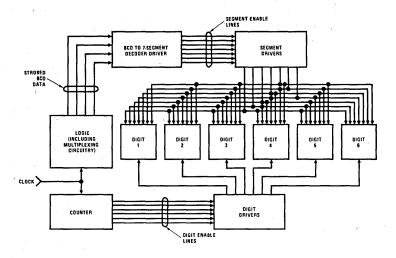


FIGURE 3. A Typical Multiplexing Scheme

and efficiency. Thus the system designer needs a degree of latitude not only with respect to the type of display used but also the drive current available.

7-segment LEDs can be purchased in either single or multi-digit display packages. Single digit displays have individual segment and common pins while multi-digits have paralleled segment pins and separate digit pins equal to the number of digits in the package, see Figure 2.

Multi-digit displays, due to their configuration, must be driven in a multiplex mode of drive, where segment drivers are time shared by all the digits. This is contrasted to the single digit displays which

may be driven in either the multiplex or the nonmultiplex (direct drive) mode. The nonmultiplex mode uses separate segment drivers for each digit of the display. Multiplex operation has a decided cost saving advantage over nonmultiplex operation especially when the number of digits being driven is large.

#### MODES OF 7-SEGMENT LED DRIVE

In the multiplex mode of drive the LED digits in a multi-digit format are driven by a single set of segment drivers while each digit is selected by its own digit driver. Figure 3 shows the circuitry needed to implement a typical six digit multiplexed display.

Each digit is selected individually by enabling its digit driver whose control is determined by a counter or equivalent circuitry operating at some clock frequency. Strobed data, by way of the counter and multiplex circuitry, is then displayed on the selected digit by the single set of segment drivers. If the strobe rate is high enough, from about 250 to 1,000 Hz depending on external conditions, the display will appear flicker free to the human eye. The BCD-to-7-segment decoder converts BCD data to the desired 7-segment output format.

In the multiplex mode each digit has a reduced duty cycle and is operated at somewhat higher than average or typical dc operating current levels. The amount of current will be a function of the number of digits, duty cycle, and the type and efficiency of the display used. Since currents are higher than average so also will be the LED brightness due to the nearly linear brightness versus current curve for most LEDs. The human eye will detect the brightness peaks and through a partially integrating and peak detecting action will perceive a higher display brightness at some average current level in the multiplex mode than the same average current in the nonmultiplex (direct drive) mode. The result is that a multiplexed display will operate at a lower total power than the same display operated in the nonmultiplex mode with the same apparent brightness.

In the nonmultiplex mode of 7-segment LED drive each digit has its own set of segment drivers thereby dropping the digit driver select requirement of multiplexed operation. In this case, the common digit pin may be tied to the highest potential if common anode or the lowest if common cathode. It is evident that in a nonmultiplexed display the driver package count would be high since each digit requires its own set of segment and possibly decoder drivers. If a large number of digits are used the segment driver package count would equal the number of digits while in the multiplex mode this count is equal to one. Granted, in the multiplex mode additional control circuitry is required. Consideration of the relative cost of this circuitry in comparison to the segment decoder driver circuitry in the nonmultiplex mode results, in general, in the fact that if the number of digits in the display equals or is more than four, total package count and/or cost is less in the multiplex mode of drive.

In most MOS circuits multiplex operation is ideal since the counter, multiplexer, and BCD to 7-segment decoders or equivalent circuitry can usually be incorporated on the same chip along with calculator, clock or other function. In this case the only external interface components required would be the digit and segment drivers since MOS circuits are generally unable to sink or source the higher current required for most multiplex operations.

In summary, LED driver requirements for multiplex or nonmultiplex drive operation require either segment, digit or BCD to 7-segment drivers. Analysis of the particular system needs with regard to the number of digits and relative circuit costs should be the determining factor for multiplex or nonmultiplex operation. Circuit requirements for multiplex operation will in general require relatively high current capabilities.

#### NATIONAL'S 7-SEGMENT LED DRIVERS

Table I lists the 7-segment LED drivers available from National. Each circuits application is divided into groupings with respect to common anode or cathode, digit or segment, multiplex or nonmultiplex areas. Additionally, current capabilities are also specified for each product.

From the table it is evident that some of the circuits may be used in dual roles — both multiplex or nonmultiplex; common cathode or anode. In general, what will determine whether one drivers application is multiplex or nonmultiplex is that drivers current capability. The direction of current flow through the driver (source or sink) is the determining factor in dual application with regard to common anode or cathode.

Table II lists the operating temperature range and package types for the 7-segment LED drivers.

In the following sections each circuit is described in greater detail and typical applications are given.

#### **BCD TO 7-SEGMENT DECODER DRIVERS**

## DM5446A/DM7446A, DM5447A/DM7447A, DM5448/DM7448

This family of BCD to 7-segment decoder drivers was designed for the most general possible display drive applications including display technologies other than LEDs. The difference between the circuits is in their output stage configurations. These differences will be discussed separately later.

The circuits convert the standard 4-bit BCD input to the popular 7-segment output format. All input BCD codes above 9 are decoded into unique patterns that verify operation. The circuits are TTL-DTL compatible and operate off of a single 5.0V supply.

Added features included in all circuits are a ripple blanking input pin as well as a lamp test pin for display turn on. In addition the blanking input/ripple blanking output pin may be used to modulate display intensity.

TABLE I. National 7-Segment LED Drivers

DEVICE	COMMO	N CATHODE	соммо	ON ANODE	DIGIT	SEGMENT	INTERNAL	CURRENT CAPABILITY
NUMBER	Multiplex	Nonmultiplex	Multiplex	Nonmultiplex	DRIVER	DRIVER	DECODING	AND FEATURES
DM5446A/DM7446A DM5447A/DM7447A			х	×		x	×	Up to 40 mA Sink, Open Collector High Breakdown (30/15V) TTL Input Compatibility
DM5448/DM7448		<b>x</b> .	x.	x*		x	×	1.3 mA Source, Adjustable Externally, TTL Input Compatibility
DM7856/DM8856		. <b>X</b>	x*	X*		×	х.	6.0 mA Typical Source, TTL Input Compatibility
DM8857	×	x		!		x	×	50 mA Typical Source, Exter- nally Adjustable, TTL Input Compatibility
DM7858/DM8858	×	x				×	×	Adjustable Source Current 0 to 50 mA, TTL Input Compatibility patibility
DM75491	×	x	<b>x</b>	x	×	×		50 mA Source/Sink, 4 Drivers per Package, MOS Input Com- patibility
DM75492	×		x	x	×	×**	!	250 mA Sink, 6 Drivers per Package, MOS Input Compatibility
DM8861 .	×	х -	, <b>x</b>	, <b>x</b>	x	×		50 mA Source/Sink, 5 Drivers per Package, MOS Input Compatibility
DM8863	×		x	х	×	x**		500 mA Sink, 8 Drivers per Package MOS Input Compatibility
DM8864	×		x	X	х	x**	,	50 mA Sink, 9 Drivers per Package, MOS Input Compatibility
DM8865	×		, <b>x</b>	<b>x</b>	x	x**		50 mA Sink, 8 Drivers per Package, MOS Input Compatibility
DM8866	×		×	×	×	x**		50 mA Sink, 7 Drivers per Package, MOS Input Compatibility

<sup>\*</sup>With the use of an external transistor/segment.

TABLE II. Operating Temperature Range and Package Type

DEVICE		OPERATING TEMPERATURE RANGE			NS	PACKAGE TYPE			
NUMBER ·	0°C to +70°C	-55°C to +125°C	14	16	18	Plastic Molded DIP (N)	Ceramic DIP (J)	Flat Pack (W)	
DM5446A, DM5447A		×		х			х	х .	
DM7446A, DM7447A	×			×	1	×	x	х	
DM5448		×		×	)		×	×	
DM7448	×			×	Ì	×	×	x	
DM7856		×		×	Ì	1	×	×	
DM8856	×			×	l	×	×	×	
DM8857	· ×	;		×	)	}	×		
DM7858 ·		×		×	1		, <b>x</b>	×	
DM8858	×	1		×	i .	×	x	· x	
DM75491	×		×	ł	l	×	x	×	
DM75492	×	ŀ	×			×	×	×	
DM8861	×				×	×			
DM8863	×			1	×	×			
DM8865	×			ł	×	×			
DM8866	×			ļ	×	) x		}	
DM8864	×			22		1 ×		1	

<sup>\*\*</sup>For common anode LED's.

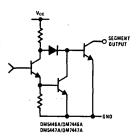


FIGURE 4a. Output Stage

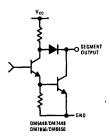
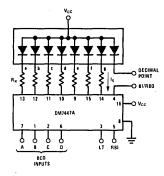


FIGURE 4b. Output Stage



THE FOLLOWING EQUATION MAY BE USED TO DETERMINE THE APPROPRIATE VALUE

(I<sub>S</sub> ≤ 40 mA)

WHERE  $V_{LED}$  ( $\wp$   $I_S$ ) is the diode (LED) voltage drop at operating current  $I_S$ .

MPL E:

V<sub>LED</sub> (@ I<sub>S</sub>) = 3.4V

V<sub>CC</sub> = 5.0V

R. • 650

MAN-1 OR EQUIVALENT

FIGURE 5. Nonmultiplex Application of the DM7447A

#### DM5446A/DM7446A, DM5447A/DM7447A

These circuits feature active-low, open collector high current outputs (Figure 4a). Each output is capable of sinking up to 40 mA at a maximum internal drop of 0.4V. This high current capability makes these circuits particularly well suited for driving the large MAN-1 or equivalent type displays directly. The circuits are also applicable, with or without the use of external current limit resistors, to driving lower current displays in the multiplex mode of drive.

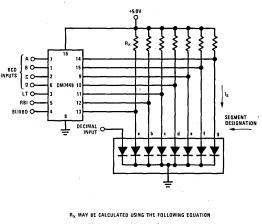
The DM5446A and DM7446A outputs are capable of withstanding 30V at a maximum leakage of 250µA over temperature. The DM5447A and DM7447A have a 15V output capability at a maximum leakage over temperature of 250µA. This standoff voltage ability makes the circuits applicable for direct drive to indicator lamp type displays. Figure 5 shows a typical application of the circuits with LEDs.

Refer to Table II for the operating temperature range and package types for the DM5446A/DM7446A and DM5447A/DM7447A.

#### DM5448/DM7448

The DM5448/DM7448 has active high passive pull-up outputs (Figure 4b) with a TTL fanout of 4. The typical output source current is 2.0 mA at an output voltage of 0.85V. Each output is capable of sinking 6.4 mA with a maximum internal drop of 0.4V. Since the output current level is low the circuit can be used to drive low current common cathode displays operating in the nonmultiplex mode.

The major application of the DM5448/DM7448 is to drive logic circuits, operate high-voltage loads such as electroluminescent displays through buffer transistors or SCR switches, or high-current



 $R_X$  MAY BE CALCULATED USING THE FOLLOWING EQUATION  $R_X = \frac{5.0 - V_{\rm LED}}{I_S - 1.6} ~ k\Omega = \frac{3.3}{I_S - 1.6} ~ k\Omega - \frac{V_{\rm LED}}{R_X} \gtrsim 650\Omega$  WHERE:  $R_X = PULL-UP ~RESISTOR~VALUE$   $I_S = CUBRENT ~PER~SEGMENT~IN~mA$  EXAMPLE:

I<sub>S</sub> = 5.0 mA

R<sub>x</sub> = 970Ω

FIGURE 6. Nonmultiplex Application of the DM7448

loads through buffer transistors. Figure 6 shows the DM7448 in a low current direct drive LED application.

The operating temperature range and package types for the DM5448/DM7448 are given in Table II.

#### BCD TO 7-SEGMENT LED DRIVERS DM7856/DM8856, DM8857, DM7858/DM8858

This series of three circuits was designed to provide a wide range of current capabilities in driving common cathode 7-segment LEDs operating in the multiplex or nonmultiplex mode. The circuits, discussed individually below, have output stages with varying source current capability designed for specific as well as general applications.

All circuits accept 4-bit BCD and decode this input to the desired 7-segment output format for direct drive to LEDs. In addition, the circuits feature a lamp test pin for display turn-on check, ripple blanking-input pin and blanking input/ripple blanking output pin which may be used to modulate display intensity.

The three circuits are TTL-DTL compatible and provide full decoding of the 16 possible input combinations. All parts operate off of a single 5.0V supply.

#### DM7856/DM8856

The DM7856/DM8856 output stages, passive-pullup (active high, Figure 4b), provide a typical

source current of 6.0 mA at an output voltage of 1.7V. This current level was designed for directly driving, without the use of external current limit resistors, the MAN-4 or equivalent type displays in the nonmultiplex mode of operation.

Each output has a fan-out of 4 and is capable of sinking 6.4 mA with a maximum internal drop of 0.4V making the circuit suitable for use with logic circuits. With the use of an external buffer transistor per output the circuit may be used to drive high current common anode LED displays as well as high voltage electroluminescent displays. Figure 7 shows a typical application of the DM8856.

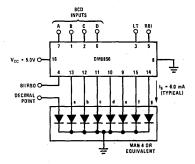


FIGURE 7. Nonmultiplex Application of the DM8856

Operating temperature range and package types for the DM7856/DM8856 are given in Table II.

#### DM8857

The output stages of the DM8857, active pull-up (active-high, Figure 4c), source a typical current

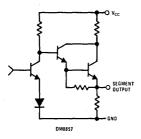


FIGURE 4c. Output Stage

of 50 mA at an output voltage of 2.3V. The circuit was designed to be used with MAN-4 or equivalent type displays operating in the multiplex mode of drive. With this high current capability the circuit can drive up to 16 such digits.

The applications of this circuit obviously are not limited to just the MAN-4 type of display. Common cathode displays with high dc current requirements or lower multiplex current levels may be driven by this circuit with the use of an external current limit resistor per segment. A typical application of the DM8857 is given in Figure 8.

Table II gives the operating temperature range and package type for the DM8857.

#### DM7858/DM8858

The DM7858/DM8858 output stages are active pull-up (active-high, Figure 4d) like those of the

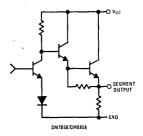
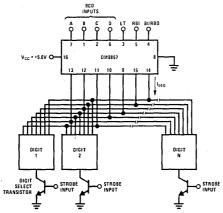


FIGURE 4d. Output Stage

DM8857. The output stages are exactly the same as the DM8857 except that the internal current limit resistor per output has been removed. External current limit resistors must then be used. This allows the circuit to be customized for a particular common cathode multiplex or non-multiplex application. Each output stage, through its own external resistor, can be programmed to some current from 50 mA down to 0 mA. Care must be taken in not shorting the outputs to ground because of the excessive current flow that would result from the Darlington upper stage. See Figure 9 for a typical application of the DM8858.



FOR MULTIPLEX OR NONMULTIPLEX APPLICATIONS WHERE AN EXTERNAL CURRENT LIMIT RESISTOR PER SEGMENT IS REQUIRED SEE THE OUTPUT CURRENT VS VOLTAGE CURVE FOR THE DM8857 AND USE THE EQUATION GIVEN IN FIGURE 9 TO CALCULATE

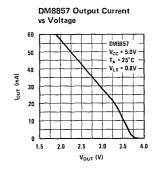


FIGURE 8. DM8857 Typical Multiplexing Scheme



Maximum output source current per segment for the DM7858/DM8858 is 50 mA. Operating temperature range and package types are given in Table II.

Special care must be taken in the use of the DM7858 ceramic and the DM8858 plastic DIP's with regard to not exceeding the maximum operating junction temperature of the devices. The maximum junction temperature of the DM7858J is 150°C and must be derated based on a thermal resistance of 80°C/Watt, junction to ambient. The maximum junction temperature for the DM8858N is 150°C and must be derated based on a thermal resistance of 140°C/Watt, junction to ambient.

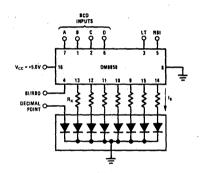
## DM75491, DM8861 MOS TO LED SEGMENT DRIVERS

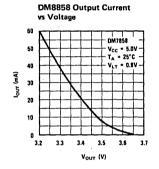
The DM75491 and DM8861 were designed for MOS calculator applications. Both circuits feature

low input current, 3.3 mA maximum at 10V input, making them suitable for direct drive from MOS circuits. The circuits are used to drive the paralleled segments in multi-digit displays. Since both circuits feature accessable collectors and emitters they may be used as either common cathode or anode segment drivers. They feature a source or sink current capability of up to 50 mA with a maximum collector to emitter drop of 1.5V over the operating temperature range. In addition, each output is specified to have a maximum leakage of 100µA at an output voltage of 10V over temperature. Both circuits operate from a single supply that can have a maximum voltage of 10V.

#### DM75491 FOUR SEGMENT DRIVER

The DM75491 is a four segment driver whose main application is with multi-digit LEDs operating in the multiplex mode of drive. Each package contains four separate segment drivers, each driver





TO FIND THE APPROPRIATE VALUE OF THE SEGMENT CURRENT LIMIT RESISTOR  $\mathbf{R}_{\mathbf{X}}$  The Following equation should be used.

WHERE:

Is - SEGMENT CURRENT

VD - LED DIODE DROP AT CURRENT IS

VOUT - DM8858 OUTPUT VOLTAGE AT CURRENT IS (SEE GRAPH)

EXAMPLE:

Is = 5.0 mA

V<sub>D</sub> = 1.7V (AT 5.0 mA)

FROM GRAPH (V<sub>CC</sub> = 5.0V, T<sub>A</sub> = 25°C)

V<sub>OUT</sub> = 3.53V (AT 5.0 mA)

•

5.0

THE SAME EQUATION MAY BE USED WHEN EITHER THE DM7858 OR THE DM8858 ARE DFEASTING IN THE MULTIPLEX MODE OF DRIVE. IF THE ADDITIONAL VOLTAGE DROP DUE TO THE DIGIT DRIVER IS TAKEN INTO CONSIDERATION THE NEW EQUATION WOULD HAVE THE FOLLOWING FORM:

VOUT - VD - VDR

VDR - DIGIT DRIVER DROP AT CURRENT I

FIGURE 9. DM8858 Applications

with free collector and emitter points, see Figure 4e.

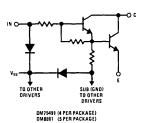


FIGURE 4e. Circuit Schematic

In the multiplex mode of drive, a six digit calculator needs only two DM75491's to drive the segments in the display, see Figure 10. The total of eight segment drivers allows drive to each of the individual seven segments plus logic control for the decimal point. Figure 11 shows the DM75491 used in an 8 digit calculator application.

Table II lists the package type and temperature range of the DM75491.

#### DM8861 FIVE SEGMENT DRIVER

The DM8861 is a five segment driver which like the DM75491 is used with multi-digit LEDs operating in the multiplex mode of drive. Each package contains five separate drivers, each driver with free collector and emitter points, Figure 4e.

A typical application of the DM8861 is given in Figure 11 where the DM8861 is combined with the DM75491 to provide a total of nine independent sources of LED segment current from an MOS calculator. This allows control of the 7-segments plus decimal point and minus sign. This combination of circuits is not solely applicable to just the 8 digit calculator configuration shown but can be used with a display having as many digits as desired as long as the multiplexed segment current requirement does not exceed 50 mA.

As with the DM75491, the DM8861 is also applicable to use with common anode displays as well as common cathode since each driver has its collector bonded out to a separate pin.

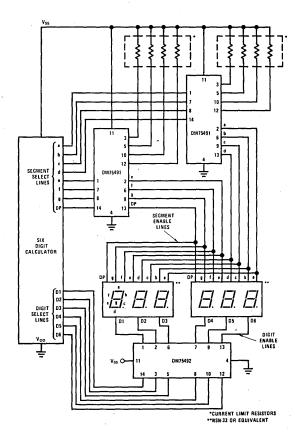


FIGURE 10. 6-Digit Calculator

Refer to Table II for operating temperature range and package type for the DM8861.

## DM75492, DM8863 MOS TO LED DIGIT DRIVERS

The DM75492 and DM8863 are digit drivers designed to drive multi-digit common cathode LEDs directly from MOS circuits. Since digit currents are quite high in multiplex operation MOS circuits usually cannot sink the required digit select current, therefore these circuits provide the required current buffering. The two circuits have different current handling capability as well as different numbers of drivers per package, each will be discussed individually later.

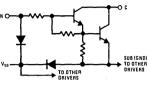
The circuits are totally compatible for use with both the DM75491 and the DM8861. The most common usage of the circuits is in MOS calculator applications where the DM75491 or the DM8861 source the segment current and either the DM75492 or the DM8863 sink the digit current.

#### DM75492 SIX DIGIT DRIVER

The DM75492 is a six digit LED driver designed to be used with common cathode multi-digit

displays operating in the multiplex mode of drive.

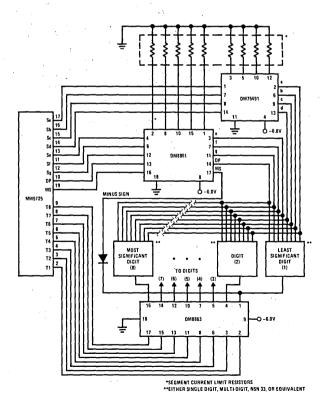
The circuit features six high gain Darlington connected transistors, with collectors open and emitters tied to ground (Figure 4f), capable of



DM75492 (6 PER PACKAGE) DM8863 XR PER PACKAGE

FIGURE 4f. Circuit Schematic

sinking up to 250 mA with a maximum collector to ground drop of 1.5V over the operating temperature range. Low input current of 3.3 mA maximum at 10V makes the drivers suitable for direct connection to MOS circuits. Output leakage is  $200\mu A$  maximum at 10V over temperature. Maximum  $V_{CC}$  is 10V.



5-182

6

In Figure 10 the DM75492 is shown along with the DM75491 in a typical six digit calculator application. Since the calculator circuit shown is operated in the multiplex mode of drive only one DM75492 is required, replacing at least six transistors and resistors for the equivalent discrete circuit.

The operating temperature range and package type for the DM75492 is given in Table II.

#### DM8863 EIGHT DIGIT DRIVER

The DM8863 is an eight digit LED driver designed to be used in conjunction with either the DM75491 and/or the DM8861 in driving eight common cathode LED digits operating in the multiplex mode of drive.

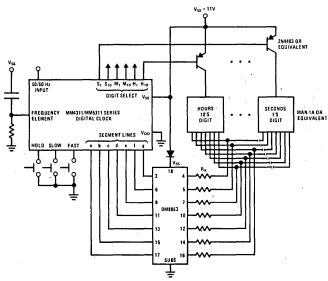
This circuit features eight separate high gain Darlington connected transistor circuits, see Figure 4f. Each Darlington transistor pair is capable of sinking 500 mA with a maximum collector to ground drop of 1.6V. Each collector can withstand

10V at a maximum leakage of  $250\mu A$  in the off state. Maximum input current is 2.0 mA at 10V, making the circuit particularly well suited for direct drive from MOS circuits.

Figure 11 shows the DM8863 used in a typical 8-digit calculator application. The important feature of the DM8863 is the very high sink current capability. This allows multiplex operation of large digits or large numbers of digits without the use of discrete high current transistors.

Another application of the DM8863 is shown in Figure 12. In this case the DM8863 is used along with the MM4311/MM5311 series digital clock circuits in the implementation of a 6-digit clock display. Here the DM8863 is used as a segment driver for a common anode display. The use of the DM8863 in this manner replaces a total of 14 resistors and 7 transistors.

The DM8863 uses a single supply with a maximum voltage of 10V. Table II specifies the operating temperature range and package type for the DM8863.



Rx - 200, VARIABLE DEPENDING ON DESIRED DISPLAY BRIGHTNESS.

FIGURE 12. Digital Clock Using DM8863

#### DM8864, DM8865, DM8866 MOS TO LED DIGIT DRIVERS

The DM8864, DM8865, and DM8866 were designed to drive common cathode nine, eight, and seven digit displays respectively. The applications of these drivers are similar to those of the DM75492 and DM8863 except that operating current levels are lower.

All circuits feature maximum input current of 2.0 mA at a voltage of 6.5V. Output sink capability is 50 mA at a maximum collector to ground drop of 1.5V. Output leakage is  $40\mu A$  (max) at an output voltage of 6.0V. All circuits operate from a supply that can vary from 5.0V to 9.5V.

#### DM8864 NINE DIGIT DRIVER

The DM8864 is a nine digit common cathode LED driver. Each package contains nine separate digit drivers. The circuit also features a "low battery" indicator driver which will light a decimal point whenever a 9.0V battery drops below 6.5V typical.

Figure 13 shows the DM8864 in a typical calculator drive application. The operating temperature range

and package type for the DM8864 is given in Table II.

#### DM8865 EIGHT DIGIT DRIVER

The DM8865 is an eight digit common cathode LED driver. Eight separate drivers are contained within each package. As with the DM8864 and DM8866 the DM8865 can also be used as a segment driver for common anode displays in the multiplex or nonmultiplex mode as long as the segment current does not exceed 50 mA.

Table II gives the operating temperature range and package type for the DM8865.

#### DM8866 SEVEN DIGIT DRIVER

The DM8866 is a seven digit common cathode LED driver. Each package contains seven separate digit drivers. Logic is also provided for a "low battery" indicator which will detect a 9.0V battery drop to below 6.5V typical and drive a decimal point.

Table II lists the package type and temperature range of the DM8866.

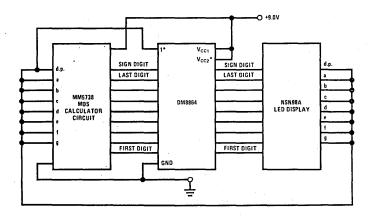


FIGURE 13. A Typical Application of the DM8864, Showing a Complete 8-Digit, 5 Function Calculator with Memory.



# Section 6 **Memory Support**



TEMPERAT – 55°C to + 125°C	URE RANGE 0°C to +70°C	DESCRIPTION	PAGE NUMBER
	DS0025C	2-Phase PMOS Clock Driver	6-4
*DS0026	DS0025C DS0026C	2-Phase PMOS Clock Driver	6-7
*DS0056	DS0026C DS0056C	2-Phase PMOS Clock Driver	6-7
D30000	DS3245	Quad MOS Clock Driver	6-14
DS1617	DS3617	Bubble Memory Sense Amplifier	6-17
*DS1628	DS3628	Octal TRI-STATE MOS Driver	6-24
*DS1644	DS3644	Quad TTL-to-MOS Clock Drivers	6-27
*DS1674	DS3674	Quad TTL-to-MOS Clock Drivers	6-27
*DS1645	DS3645	Hex TRI-STATE TTL-to-MOS Latch/Drivers	6-30
*DS1675	DS3675	Hex TRI-STATE TTL-to-MOS Latch/Drivers	6-30
*DS1647	DS3647	Quad TRI-STATE I/O Registers	6-35
*DS1677	DS3677	Quad TRI-STATE I/O Registers	6-35
*DS16147	DS36147	Quad TRI-STATE I/O Registers	6-35
*DS16177	DS36177	Quad TRI-STATE I/O Registers	6-35
*DS1648	DS3648	TRI-STATE TTL-to-MOS Multiplexer/Driver	6-41
*DS1678	DS3678	TRI-STATE TTL-to-MOS Multiplexer/Driver	6-41
*DS1649	DS3649	Hex TRI-STATE TTL-to-MOS Driver	6-46
*DS1679	DS3679	Hex TRI-STATE TTL-to-MOS Driver	6-46
*DS1651	DS3651	Quad High Speed MOS Sense Amplifiers	6-49
*DS1653	DS3653	Quad High Speed MOS Sense Amplifiers	6-49
*DS1671	DS3671	Dual Bootstrapped 2-Phase Clock Driver	6-55
	DS3685	Hex TRI-STATE Latch	6-59
*DS16149	DS36149	Hex MOS Drivers	6-62 <sup>-</sup>
*DS16179	DS36179	Hex MOS Drivers	6-62
*DS55325	DS75325	Memory Drivers	6-66
	DS75361	Dual TTL-to-MOS Driver	6-73
	DS75362	Dual TTL-to-MOS Driver	6-78
-	DS75365	Quad TTL-to-MOS Driver	6-83
<del>_</del>	AN-76	Applying Modern Clock Drivers to MOS Memories	6-88

<sup>\*</sup>Also available screened in accordance with MIL-STD-883 Class B. Refer to National Semiconductor's "The Reliability Handbook".



### 4k & 16k N-CHANNEL MOS MEMORY INTERFACE CIRCUITS

Page No.	Device Number and Name	5V Clock Drivers	12V Clock Drivers	4k RAM Address Drivers	16k RAM Address Drivers	Data I/O	Timing & Control Drivers
6-17	DS3617						1
	Bubble Memory Sense Amplifier	1				}	
6-24	DS3628	•			•	ļ	•
,	Octal TRI-STATE® MOS Driver	ł	ł			<u> </u>	
6-27	DS3644, DS3674	<u> </u>	•			1	
	Quad MOS Clock Driver		]		,	ł	
6-14	DS3245	ł	•		}	i	•
	Quad MOS Clock Driver	1	}		Ì	l	-
6-30	DS3645, DS3675		Ì	•	[	ĺ	
	Hex TRI-STATE MOS Driver Latch	ł	ļ		}	1	
6-35	DS3647, DS3677, DS36147, DS36177	1	}		ĺ	•	
	Quad TRI-STATE MOS Memory I/O Register	[					
6-41	DS3648, DS3678	•	ļ	•	•	İ	•
	TRI-STATE MOS Multiplexer/Driver	<b>}</b>	<u> </u>	ĺ			
6-46	DS3649, DS3679	•	Į	•		1	•
	Hex TRI-STATE MOS Driver		}		}	j	1
6-59	DS3685	ł	1		1	l	
	Hex TRI-STATE Latch	į	ĺ			1	
6-62	DS36149, DS36179	•	}	•	}	İ	•
	Hex MOS Driver		ł		}	1	
6-66	DS75325	İ	Ì	ļ			ļ
	Memory Driver	<b>[</b>	}	j		}	
6-73	DS75361	1	•	,	Ì	Ì	
	Dual TTL-to-MOS Driver	Ì	Ì		}		
6-78	DS75362		• .	1	}	1	Ì
	Dual TTL-to-MOS Driver	ł	1		l	l	1
6-83	DS75365		•		1		}
	Quad TTL-to-MOS Driver	}	1			1	į
2.5	DP8303, DP8304B, DP8307, DP8308	ì	<b>!</b> .		1	•	
	8-Bit Bidirectional Transceiver	1	<b>!</b>		1	ł	
8-11	DP8216, DP8226		}		1	•	
	4-Bit Bidirectional Transceiver		ĺ	Ì			
2-89	DS8T26, DS8T28	1	{			. •	
	Quad TRI-STATE Bus Driver	1	1		}	1	
8-4	DP8212	}	}		1	•	
	8-Bit Input/Output Port	İ	l	<u> </u>	<b>!</b>	1	

# P-CHANNEL MOS INTERFACE CIRCUITS

FUNCTION	CHARACTERISTICS	TEMPE	PAGE NO.	
- TONCTION	CHARACTERISTICS	0°C to +70°C	-55°C to +125°C	PAGE NO.
Clock Driver	Dual, 30V, Drive 1000 pF @ 1 MHz	DS0025C		6-4
Clock Driver	Dual, 20V, Drive 1000 pF @ 5 MHz	DS0026C	DS0026	6-7
Clock Driver	Same as DS0026, May Use Pull-Up Resistor	DS0056C	DS0056	6-7
Clock Driver	Same as DS0026, May Be Bootstrapped	DS3671	DS1671	6-55
Differential Sense Amplifier	Quad TRI-STATE ±7 mV Sensitivity	D\$3651	DS1651	6-49
Differential Sense Amplifier	Quad Open-Collector ±7 mV Sensitivity	DS3653	DS1653	6-49

Note. Refer to Application Note 76 for additional information on clock drivers.

# **Memory Support**

# **DS0025C Two Phase MOS Clock Driver**

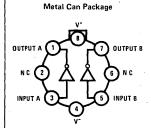
# **General Description**

The DS0025C is a monolithic, low cost, two phase MOS clock driver that is designed to be driven by TTL line drivers or buffers such as the DS8830 or DM7440. Two input coupling capacitors are used to perform the level shift from TTL to MOS logic levels. Optimum performance in turn-off delay and fall time are obtained when the output pulse is logically controlled by the input. However, output pulse widths may be set by selection of the input capacitor eliminating the need for tight input pulse control.

### **Features**

- 8-lead TO-5 or 8-lead or 14-lead dual-in-line package
- High Output Voltage Swings-up to 30V
- High Output Current Drive Capability-up to
- Rep. Rate: 1.0 MHz into > 1000 pF
- Driven by DS8830, DM7440
- "Zero" Quiescent Power

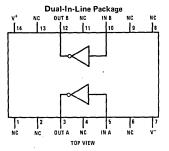
# Connection Diagrams



Note: Pin 4 connected to case TOP VIEW Order Number DS0025CH See NS Package H08C

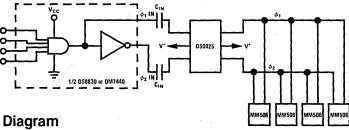
Dual-In-Line Package OUTPUT A INPUT A 2 5 OUTPUT B INPIIT R 4 TOP VIEW

Order Number DS0025CN or DS0025CJ-8 See NS Package N08A or J08A

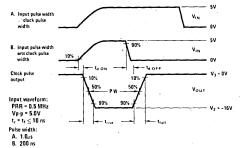


Order Number DS0025CJ See NS Package J14A

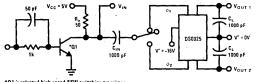
# Typical Application



# Timing Diagram



### **AC Test Circuit**



\*Q1 is selected high speed NPN switching transistor

# Absolute Maximum Ratings (Note 1)

(V <sup>+</sup> - V ) Voltage Differential	30V
Input Current	100 mA
Peak Output Current	1.5A
Storage Temperature	$-65^{\circ}$ C to $+150^{\circ}$ C
Operating Temperature	$0^{\circ}$ C to $+85^{\circ}$ C
Lead Temperature (Soldering, 10 sec)	300°C

Maximum Power Dissipation\* at 25°C

8-Pin Cavity Package 1150 mW 14-Pin Cavity Package 1410 mW Molded Package 1080 mW Metal Can (TO-5) Package 670 mW

\*Derate 8-pin cavity package 7.8 mW/°C above 25°C; derate 14-pin cavity package 9.5 mW/° C above 25° C; derate molded package 8.7 mW/°C above 25°C; derate metal can (TO-5) package 4.5 mW/°C above 25°C.

# Electrical Characteristics (Notes 2 and 3) See test circuit.

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
tdON	Turn-On Delay Time	$C_{IN} = 0.001 \mu F, R_{IN} = 0\Omega, C$	$C_{IN} = 0.001 \mu F, R_{IN} = 0\Omega, C_L = 0.001 \mu F$		15	30	ns
tRISE	Rise Time	$C_{IN} = 0.001 \mu F, R_{IN} = 0\Omega, C$	L = 0.001μF		25	50	ns
t <sub>d OFF</sub>	Turn-Off Delay Time	$C_{1N} = 0.001 \mu F$ , $R_{1N} = 0\Omega$ , $C_L = 0.001 \mu F$ (Note 4)			30	60	ns
t <sub>FALL</sub>	Fall Time	$C_{IN} = 0.001 \mu F, R_{IN} = 0\Omega,$	(Note 4)	60	90	120	ns
		C <sub>L</sub> = 0.001μF	(Note 5)	100	150	250	ns
PW	Pulse Width (50% to 50%)	$C_{IN} = 0.001 \mu F, R_{IN} = 0\Omega,$ $C_L = 0.001 \mu F \text{ (Note 5)}$			500		ns
V <sub>O+</sub>	Positive Output Voltage Swing	V <sub>IN</sub> = 0V, I <sub>OUT</sub> = -1 mA		V <sup>+</sup> −1.0	V <sup>+</sup> -0.7V		٧
Vo-	Negative Output Voltage Swing	I <sub>IN</sub> = 10 mA, I <sub>OUT</sub> = 1 mA			V <sup>-</sup> +0.7V	V <sup>-</sup> +1.5V	V

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

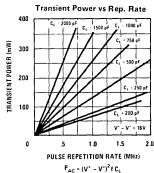
Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range for the DS0025C.

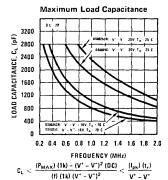
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

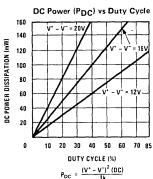
Note 4: Parameter values apply for clock pulse width determined by input pulse width.

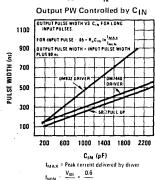
Note 5: Parameter values for input pulse width greater than output clock pulse width.

# Typical Performance









# Applications Information (Reference AN-76)

### **Circuit Operation**

Input current forced into the base of  $Q_1$  through the coupling capacitor  $C_{IN}$  causes  $Q_1$  to be driven into saturation, swinging the output to  $V^- + V_{CE}(sat) + V_{Diode}$ 

When the input current has decayed, or has been switched, such that  $\mathbf{Q}_1$  turns off,  $\mathbf{Q}_2$  receives base drive through  $\mathbf{R}_2$ , turning  $\mathbf{Q}_2$  on. This supplies current to the load and the output swings positive to  $\mathbf{V}^+ - \mathbf{V}_{BE}$ .

It may be noted that  $Q_1$  must switch off before  $Q_2$  begins to supply current, hence high internal transients currents from  $V^-$  to  $V^+$  cannot occur.

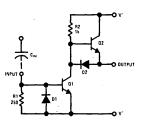


FIGURE 1. DS0025 Schematic (One-Half Circuit)

### Fan-Out Calculation

The drive capability of the DS0025 is a function of system requirements, i.e. speed, ambient temperature, voltage swing, drive circuitry, and stray wiring capacity.

The following equations cover the necessary cal-

culations to enable the fan-out to be calculated for any system condition.

### **Transient Current**

The maximum peak output current of the DS0025 is given as 1.5A. Average transient current required from the driver can be calculated from:

$$I = \frac{C_{L} (V^{+} - V^{-})}{t_{r}}$$
 (1)

Typical rise times into 1000 pF load is 25 ns For  $V^+ - V^- = 20V$ , I = 0.8A.

### Transient Output Power

The average transient power  $(P_{ac})$  dissipated, is equal to the energy needed to charge and discharge the output capacitive load  $(C_L)$  multiplied by the frequency of operation (f).

$$P_{AC} = C_L \times (V^+ - V^-)^2 \times f$$
 (2)

For 
$$V^+ - V^- = 20V$$
,  $f = 1.0$  MHz,  $C_L = 1000$  pF,  $P_{AC} = 400$  mW.

### Internal Power

"0" State Negligible (<3 mW)
"1" State

$$P_{int} = \frac{(V^+ - V^-)^2}{R_2} \times Duty Cycle$$
 (3)

### Package Power Dissipation

Total average power = transient output power + internal power

# **Example Calculation**

How many MM506 shift registers can be driven by a DS0025CN driver at 1 MHz using a clock pulse width of 200 ns, rise time 30-50 ns and 16V amplitude over the temperature range 0-70°C?

### Power Dissipation:

At 70°C the DS0025CN can dissipate 870 mW when soldered into printed circuit board.

### Transient Peak Current Limitation:

From equation (1), it can be seen that at 16V and 30 ns, the maximum load that can be driven is limited to 2800 pF.

### Average Internal Power:

Equation (3), gives an average power of 50 mW at 16V and a 20% duty cycle.

For one-half of the DS0025C, 870 mW  $\div$  2 can be dissipated.

435 mW = 50 mW + transient output power

385 mW = transient output power

Using equation (2) at 16V, 1 MHz and 350 mW, each half of the DS0025CN can drive a 1367 pF load. This is less than the load imposed by the transient current limitation of equation (1) and so a maximum load of 1367 pF would prevail.

From the data sheet for the MM506, the average clock pulse load is 80 pF. Therefore the number of devices driven is 1367/80 or 17 registers.

# **Memory Support**

# DS0026, DS0056 5 MHz Two Phase MOS Clock Drivers

# **General Description**

DS0026/DS0056 are low cost monolithic high speed two phase MOS clock drivers and interface circuits. Unique circuit design provides both very high speed operation and the ability to drive large capacitive loads. The device accepts standard TTL outputs and converts them to MOS logic levels. They may be driven from standard 54/74 series and 54S/74S series gates and flip-flops or from drivers such as the DS8830 or DM7440. The DS0026 and DS0056 are intended for applications in which the output pulse width is logically controlled; i.e., the output pulse width is equal to the input pulse width.

The DS0026/DS0056 are designed to fulfill a wide variety of MOS interface requirements. As a MOS clock driver for long silicon-gate shift registers, a single device can drive over 10k bits at 5 MHz. Six devices provide input address and precharge drive for a 8k by 16-bit 1103 RAM memory system. Information on the correct usage of the DS0026 in these as well as other systems is included in the application note AN-76.

The DS0026 and DS0056 are identical except each driver in the DS0056 is provided with a VBB connection to supply a higher voltage to the output stage. This aids

in pulling up the output when it is in the high state. An external resistor tied between these extra pins and a supply higher than V+ will cause the output to pull up to  $(V^+ - 0.1V)$  in the off state.

For DS0056 applications, it is required that an external resistor be used to prevent damage to the device when the driver switches low. A typical V<sub>BB</sub> connection is shown on the next page.

These devices are available in 8-lead TO-5, one watt copper lead frame 8-pin mini-DIP, and one and a half watt ceramic DIP, and TO-8 packages.

### **Features**

- Fast rise and fall times-20 ns with 1000 pF load
- High output swing-20V
- High output current drive-±1.5 amps
- TTL compatible inputs
- High rep rate-5 to 10 MHz depending on power dissipation
- Low power consumption in MOS "0" state-2 mW
- Drives to 0.4V of GND for RAM address drive

### Connection Diagrams (Top Views)

TO-5 Package

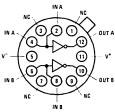
Order Number DS0026H or DS0026CH

OUT A V+ OUT B

Dual-In-Line Package

Order Number DS0026CJ-8, DS0026CN or DS0026J-8 See NS Package H08C See NS Package J08A or N08A

TO-8 Package



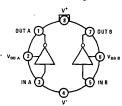
Order Number DS0026G or DS0026CG See NS Package G12C

NC OUT A

Dual-In-Line Package

Order Number DS0026J or DS0026CJ See NS Package J14A

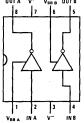
### TO-5 Package



Note: Pin 4 connected to case Order Number DS0056H

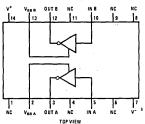
or DS0056CH See NS Package H08C

# Dual-In-Line Package



Order Number DS0056J-8. DS0056CJ-8 or DS0056CN See NS Package J08A or N08A

### Dual-In-Line Package



Order Number DS0056J or DS0056CJ See NS Package J14A

# Absolute Maximum Ratings (Note 1)

V'-V Differential Voltage	22V
Input Current	100 mA
Input Voltage (V <sub>IN</sub> - V <sup>-</sup> )	5.5V
Peak Output Current	1.5A
Maximum Power Dissipation* at 25°C	
Cavity Package (8-Pin)	1150 mW
Cavity Package (14-Pin)	1380 mW
Molded Package	1040 mW
Metal Can (TO-5) Package	660 mW

Operating Temperature Range

DS0026, DS0056

-55°C to +125°C 0°C to +70°C

DS0026C, DS0056C Storage Temperature Range

-65°C to +150°C

Lead Temperature (Soldering, 10 seconds)

300°C

\*Derate 8-pin cavity package 7.7 mW/°C above 25°C; derate 14-pin cavity package 9.3 mW/°C above 25°C; derate molded package 8.4 mW/°C above 25°C; derate metal can (TO-5) package 4.4 mW/°C above 25°C.

# Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
V <sub>IH</sub>	Logic "1" Input Voltage	V- = 0V		2	1.5		V
I <sub>IH</sub>	Logic "1" Input Current	V <sub>IN</sub> - V <sup>-</sup> = 2.4V			10	15	mA
VIL	Logic "0" Input Voltage	V <sup>-</sup> = 0V			0.6	0.4	V
I <sub>IL</sub>	Logic "0" Input Current	V <sub>IN</sub> - V <sup>-</sup> = 0V			-3 ·	-10	μА
VoL	Logic "1" Output Voltage	V <sub>IN</sub> - V <sup>-</sup> = 2.4V			V~+0.7	V~+1.0	V
V <sub>OH</sub>	Logic "0" Output Voltage	$V_{IN} - V^- = 0.4V, \ V_{BB} \ge V^+ + 1.0V$	DS0026	V <sup>+</sup> -1.0	V <sup>+</sup> -0.7		V
	1	V <sub>IN</sub> − V = 0.4V, V <sub>BB</sub> ≥ V + 1.0V	DS0056	V <sup>+</sup> -0.3	V <sup>+</sup> -0.1		V
I <sub>CC(ON)</sub>	"ON" Supply Current	$V^+ - V^- = 20V$ $V_{1N} - V^- = 2.4V$	DS0026		30	40	mA
	(one side on)	(Note 6)	DS0056		12	30	mA
I <sub>CC(OFF)</sub>	"OFF" Supply Current	V <sup>+</sup> - V <sup>-</sup> = 20V,	70°C		10	100	μΑ
	'	$V_{IN} - V^- = 0V$	125°C		10	500	μΑ

# Switching Characteristics (T<sub>A</sub> = 25°C) (Notes 5 and 7)

	PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>oN</sub>	Turn-on Delay	(Figure 1)		5	7.5	12	ns
		(Figure 2)			11		ns
toff	Turn-off Delay	(Figure 1)			12	15	· ns
		(Figure 2)			13		ns
tr	Rise Time	(Figure 1),	C <sub>L</sub> = 500 pF		15	18	ns
		(Note 5)	C <sub>L</sub> = 1000 pF		20	35	ns
		(Figure 2),	C <sub>L</sub> = 500 pF		30	40	ns
		(Note 5)	C <sub>L</sub> = 1000 pF		36	50	. ns
t <sub>f</sub>	Fall Time	(Figure 1),	C <sub>L</sub> = 500 pF		12	16	ns
		(Note 5)	C <sub>L</sub> = 1000 pF		17	25	ns
	•	(Figure 2),	C <sub>L</sub> = 500 pF		28	35	· ns
		(Note 5)	C <sub>L</sub> = 1000 pF		31	40	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

provides conditions for actual device operation.

Note 2: These specifications apply for  $V^+ - V^- = 10V$  to 20V,  $C_L = 1000$  pF, over the temperature range of -55°C to +125°C for the DS0026, DS0056 and 0°C to +70°C for the DS0026C, DS0056C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: All typical values for the  $T_A = 25^{\circ}C$ .

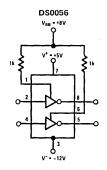
Note 5: Rise and fall time are given for MOS logic levels; i.e., rise time is transition from logic "0" to logic "1" which is voltage fall.

Note 6: IBB for DS0056 is approximately  $(V_{BB} - V^{-})/1 k\Omega$  (for one side) when output is low.

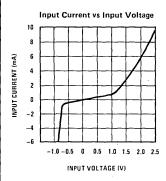
Note 7: The high current transient (as high as 1.5A) through the resistance of the external interconnecting V lead during the output transition from the high state to the low state can appear as negative feedback to the input. If the external interconnecting lead from the driving circuit to V is electrically long, or has significant dc resistance, it can subtract from the switching response.

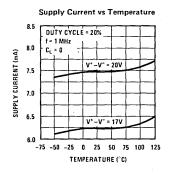
# 6

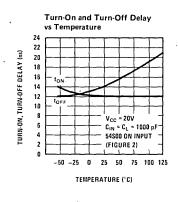
# Typical V<sub>BB</sub> Connection

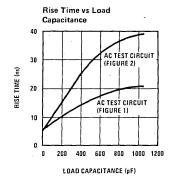


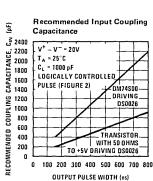
# **Typical Performance Characteristics**

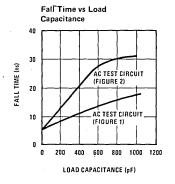


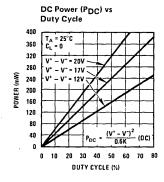






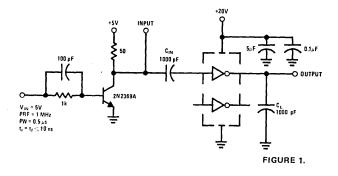


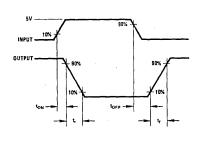


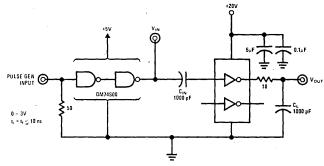


# Schematic Diagrams 1/2 DS0026 1/2 DS0056

# **AC Test Circuits and Switching Time Waveforms**







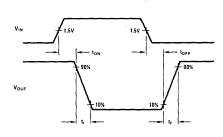
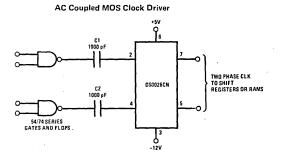
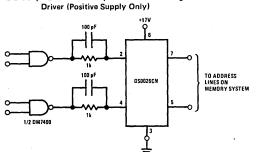


FIGURE 2.

# **Typical Applications**





DC Coupled RAM Memory Address or Precharge

# **Application Hints**

# DRIVING THE MM5262 WITH THE DS0056 CLOCK DRIVER

The clock signals for the MM5262 have three requirements which have the potential of generating problems for the user. These requirements, high speed, large voltage swing and large capacitive loads, combine to provide ample opportunity for inductive ringing on clock lines, coupling clock signals to other clocks and/or inputs and outputs and generating noise on the power supplies. All of these problems have the potential of causing the memory system to malfunction. Recognizing the source and potential of these problems early in the design of a memory system is the most critical step. The object here is to point out the source of these problems and give a quantitative feel for their magnitude.

Line ringing comes from the fact that at a high enough frequency any line must be considered as a transmission line with distributed inductance and capacitance. To see how much ringing can be tolerated we must examine the clock voltage specification. Figure 6 shows the clock



FIGURE 6. Clock Waveform

specification, in diagram form, with idealized ringing sketched in. The ringing of the clock about the  $V_{SS}$  level is particularly critical. If the  $V_{SS}-1$   $V_{OH}$  is not maintained, at all times, the information stored in the memory could be altered. Referring to Figure 1, if the threshold voltage of a transistor were -1.3V, the clock going to  $V_{SS}-1$  would mean that all the devices, whose gates are tied to that clock, would be only 300 mV from turning on. The internal circuitry needs this noise margin and from the functional description of the RAM it is easy to see that turning a clock on at the wrong time can have disastrous results.

Controlling the clock ringing is particulary difficult because of the relative magnitude of the allowable ringing, compared to the magnitude of the transition. In this case it is 1V out of 20V or only 5%. Ringing can be controlled by damping the clock driver and minimizing the line inductance.

Damping the clock driver by placing a resistance in series with its output is effective, but there is a limit since it also slows down the rise and fall time of the clock signal. Because the typical clock driver can be much faster than the worst case driver, the damping resistor serves the useful function of limiting the minimum rise and fall time. This is very important because the faster the rise and fall times, the worse the ringing problem becomes. The size of the damping resistor varies because it is dependent on the details of the actual application. It must be determined empirically. In practice a resistance of 10 ohms to 20 ohms is usually optimum.

Limiting the inductance of the clock lines can be accomplished by minimizing their length and by laying out the lines such that the return current is closely coupled to the clock lines. When minimizing the length of clock lines it is important to minimize the distance from the clock driver output to the furthest point being driven. Because of this, memory boards are usually designed with clock drivers in the center of the memory array, rather than on one side, reducing the maximum distance by a factor of 2.

Using multilayer printed circuit boards with clock lines sandwiched between the  $V_{DD}$  and  $V_{SS}$  power plains minimizes the inductance of the clock lines. It also serves the function of preventing the clocks from coupling noise into input and output lines. Unfortunately multilayer printed circuit boards are more expensive than two sided boards. The user must make the decision as to the necessity of multilayer boards. Suffice it to say here, that reliable memory boards can be designed using two sided printed circuit boards.

The recommended clock driver for use with the MM4262/MM5262 is the DS0056/DS0056C dual clock driver. This device is designed specifically for use with dynamic circuits using a substrate, V<sub>BB</sub>, supply. Typically it will drive a 1000 pF load with 20 ns rise and fall times. Figure 7 shows a schematic of a single driver.

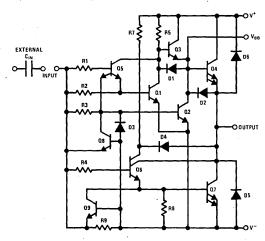


FIGURE 7. Schematic of 1/2 DS0056

In the case of the MM5262,  $^{,}$   $^{,}$  is a +5V and  $^{,}$   $^{,}$  by +8.5V.  $^{,}$   $^{,}$   $^{,}$   $^{,}$   $^{,}$  should be connected to the  $^{,}$   $^{,}$   $^{,}$  be shown in Figure 7 through a 1 k $\Omega$  resistor. This allows transistor Q4 to saturate, pulling the output to within a  $^{,}$   $^$ 

# Application Hints (Continued)

Because of the amount of current that the clock driver must supply to its capacitive load, the distribution of power to the clock driver must be considered. Figure 8 gives the idealized voltage and current waveforms for a clock driver driving a 1000 pF capacitor with 20 ns rise and fall time.

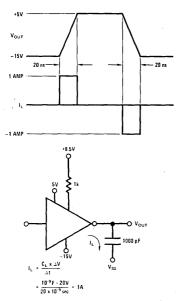


FIGURE 8. Clock Waveforms (Voltage and Current)

As can be seen the current is significant. This current flows in the  $V_{\mbox{\scriptsize DD}}$  and  $V_{\mbox{\scriptsize SS}}$  power lines. Any significant inductance in the lines will produce large voltage transients on the power supplies. A bypass capacitor. as close as possible to the clock driver, is helpful in minimizing this problem. This bypass is most effective when connected between the  $V_{SS}$  and  $V_{DD}$  supplies. A bypass capacitor for each DS0056 is recommended. The size of the bypass capacitor depends on the amount of capacitance being driven. Using a low inductance capacitor, such as a ceramic or silver mica, is most effective. Another helpful technique is to run the VDD and V<sub>SS</sub> lines, to the clock driver, adjacent to each other. This tends to reduce the lines inductance and therefore the magnitude of the voltage transients.

While discussing the clock driver, it should be pointed out that the DS0056 is a relatively low input impedance device. It is possible to couple current noise into the input without seeing a significant voltage. Since this noise is difficult to detect with an oscilloscope it is often overlooked.

Lastly, the clock lines must be considered as noise generators. Figure 9 shows a clock coupled through a parasitic coupling capacitor, C<sub>C</sub>, to eight data input lines being driven by a 7404. A parasitic lumped line

inductance, L, is also shown. Let us assume, for the sake of argument, that Cc is 1 pF and that the rise time of the clock is high enough to completely isolate the clock tranisent from the 7404 because of the inductance, L.

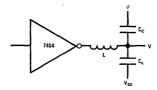


FIGURE 9. Clock Coupling

With a clock transition of 20V the magnitude of the voltage generated across C<sub>L</sub> is:

$$V = 20V \times \frac{C_C}{C_L + C_C} = 20V \times \left(\frac{1}{56 + 1}\right) = 0.35V$$

This has been a hypothetical example to emphasize that with 20V low rise/fall time transitions, parasitic elements can not be neglected. In this example, 1 pF of parasitic capacitance could cause system malfunction, because a 7404 without a pull up resistor has typically only 0.3V of noise margin in the "1" state at 25°C. Of course it is stretching things to assume that the inductance, L, completely isolates the clock transient from the 7404. However, it does point out the need to minimize inductance in input/output as well as clock lines.

The output is current, so it is more meaningful to examine the current that is coupled through a 1 pF parasitic capacitance. The current would be:

$$I = C_C \times \frac{\Delta V}{\Delta t} = \frac{1 \times 10^{-12} \times 20}{20 \times 10^{-9}} = 1 \text{ mA}$$

This exceeds the total output current swing so it is obviously significant.

Clock coupling to inputs and outputs can be minimized by using multilayer printed circuit boards, as mentioned previously, physically isolating clock lines and/or running clock lines at right angles to input/output lines. All of these techniques tend to minimize parasitic coupling capacitance from the clocks to the signals in

In considering clock coupling it is also important to have a detailed knowledge of the functional characteristics of the device being used. As an example, for the MM5262, coupling noise from the  $\phi 2$  clock to the address lines is of no particular consequence. On the other hand the address inputs will be sensitive to noise coupled from  $\phi$ 1 clock.

# **DS3245 Quad MOS Clock Driver**

# **General Description**

The DS3245 is a quad bipolar-to-MOS clock driver with TTL compatible inputs. It is designed to provide high output current and voltage capabilities necessary for optimum driving of high capacitance N-channel MOS memory systems.

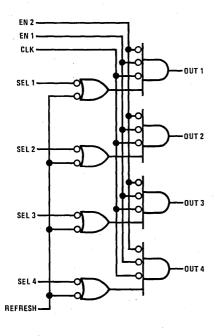
Only 2 supplies, 5 VDC and 12 VDC, are required without compromising the usual high VOH specification obtained by circuits using a third supply.

The device features 2 common enable inputs, a refresh input, and a clock control input for simplified system designs. The circuit was designed for driving highly capacitive loads at high speeds and uses Schottky-clamped transistors. PNP transistors are used on all inputs, thereby minimizing input loading.

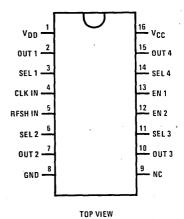
### **Features**

- **■** TTL compatible inputs
- Operates from 2 standard supplies: 5 V<sub>DC</sub>, 12 V<sub>DC</sub>
- Internal bootstrap circuit eliminates need for external PNP's
- PNP inputs minimize loading
- High voltage/current outputs
- Input and output clamping diodes
- Control logic optimized for use with MOS memory systems
- Pin and function equivalent to Intel 3245

# **Logic and Connection Diagrams**



### **Dual-In-Line Package**



Order Number DS3245J or DS3245N See NS Package J16A or N16A

# Absolute Maximum Ratings (Note 1)

Temperature Under Bias -10°C to +85°C
Storage Temperature -65°C to +150°C
Supply Voltage, VCC -0.5 to +7V
Supply Voltage, VDD -0.5 to +14V
All Input Voltages -1.0 to VDD
Outputs for Clock Driver -1.0 to VDD +1V
Maximum Power Dissipation\* at 25°C

Cavity Package 1509 mW Molded Package 1476 mW

# Electrical Characteristics TA = 0°C to +75°C, VCC = 5V ±5%, VDD = 12V ±5%

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
lFD	Select Input Load Current	V <sub>F</sub> = 0.45V			-0.25	mA
IFE	Enable Input Load Current	V <sub>F</sub> = 0.45V			-1.0	mA
IRD	Select Input Leakage Current	V <sub>R</sub> = 5V			10	μΑ
IRE	Enable Input Leakage Current '	V <sub>R</sub> = 5V			40	μА
	Output Low Voltage	IOL = 5 mA, VIH = 2V			0.45	V
VOL	Output Low Voltage	IOL = -5 mA	-1.0			V
	Owen thick Wales	I <sub>OH</sub> = -1 mA, V <sub>IL</sub> = 0.8V	V <sub>DD</sub> -0.50			V
Vон	Output High Voltage	I <sub>OH</sub> = 5 mA			V <sub>DD</sub> +1.0	V
VIL	Input Low Voltage, All Inputs	·			0.8	V
VIH	Input High Voltage, All Inputs		2			V
VCLAMP	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -12 mA		-1.0	-1.5	V

# **Power Supply Current Drain**

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
Icc	Current from V <sub>CC</sub> Output in High State	V <sub>CC</sub> = 5.25V, V <sub>DD</sub> = 12.6V		26	- 34	mA
lDD	Current from V <sub>DD</sub> Output in High State	V <sub>CC</sub> = 5.25V, V <sub>DD</sub> = 12.6V		23	30	mA
Icc	Current from V <sub>CC</sub> Output in Low State	V <sub>CC</sub> = 5.25V, V <sub>DD</sub> = 12.6V		29	39	mA
IDD	Current from V <sub>DD</sub> Output in Low State	V <sub>CC</sub> = 5.25V, V <sub>DD</sub> = 12.6V		13	19	mA

Note 1: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

<sup>\*</sup>Derate cavity package 10.1 mW/°C above 25°C; derate molded package 11.8 mW/°C above 25°C.

# Switching Characteristics $T_A = 0^{\circ}C$ to +75°C, $V_{CC} = 5V \pm 5\%$ , $V_{DD} = 12V \pm 5\%$

	PARAMETER	CONDITIONS	MIN (Note 3)	TYP (Notes 4, 6)	MAX (Note 5)	UNITS
t_+	Input to Output Delay	R <sub>SERIES</sub> = 0	5	11		ns
<sup>t</sup> DR	Delay Plus Rise Time	R <sub>SERIES</sub> = 0		20	32	ns
t+	Input to Output Delay	R <sub>SERIES</sub> = 0	3	7		ns
tDF	Delay Plus Fall Time	RSERIES = 0		18	32	ns
r.i.	Output Transition Time	RSERIES = 20Ω	10	17	25	ns
<sup>t</sup> DR	Delay Plus Rise Time	R <sub>SERIES</sub> = 20Ω		27	38	ns
†DF	Delay Plus Fall Time	R <sub>SERIES</sub> = 20Ω		25	38	ns

# Capacitance TA = 25°C (Note 7)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
CIN	Input Capacitance, $\overline{1_1}$ , $\overline{1_2}$ , $\overline{1_3}$ , $\overline{1_4}$			5	8	pF
CIN	Input Capacitance, $\overline{R}$ , $\overline{C}$ , $\overline{E}1$ , $\overline{E}2$		•	8	12	pF

Note 3: CL = 150 pF

Note 4: C<sub>L</sub> = 200 pF These values represent a range of total stray plus clock capacitance for nine 4k RAMs.

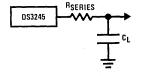
Note 5: CL = 250 pF

Note 6: Typical values are measured at 25°C.

Note 7: This parameter is periodically sampled and is not 100% tested. Condition of measurement is f = 1 MHz, V<sub>B1AS</sub> = 2V, V<sub>CC</sub> = 0V, and

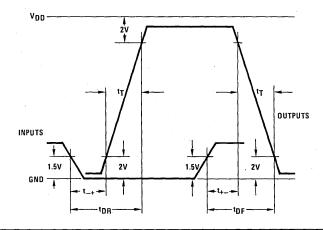
 $T_A = 25^{\circ}C$ .

# **AC Test Circuit and Switching Time Waveforms**



Input pulse amplitudes: 3V
Input pulse rise and fall times:
5 ns between 1V and 2V

Measurement points: see waveforms



# DS1617/DS3617 Bubble Memory Sense Amplifier

# **General Description**

The DS1617 and the DS3617 are bubble memory sense amplifiers that convert low level signals from magneto-resistive detectors of the bubble memory into TTL compatible output levels. Internal functions consist of an input bias circuit, an internally AC coupled amplifier, a high speed precision comparator, two flip-flops, a TRI-STATE\* output stage and a power fail detector.

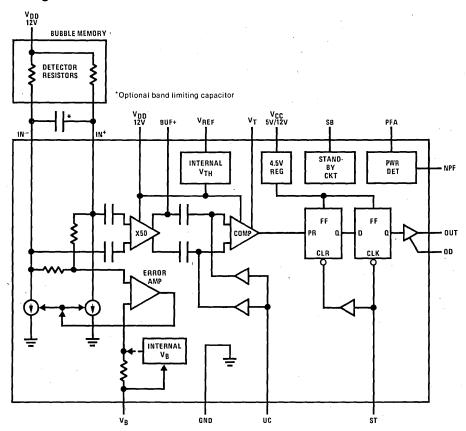
TTL compatible control inputs allow either average-topeak or the conventional clamp and strobe (peak-to-peak) sensing of the input signal. The threshold voltage and the input bias voltage are externally adjustable allowing compatibility with different types of bubble memories.

Although specifically designed for bubble memory interfacing, they are easily adaptable for any application requiring detection of mV level signals in the 25 kHz to 4 MHz range. Typical application areas include fiber optic receivers, plated wire memory sense amplifiers and pulse discriminators.

# **Features**

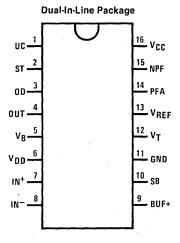
- Single 12V or 12V/5V operation
- On-chip adjustable detector bias circuit
- Choice of average-to-peak or clamp and strobe sensing
- Guaranteed tight threshold limits over the specified temperature and supply voltage range
- Threshold externally adjustable over 0 mV to 20 mV range (typical)
- On-chip reference for a 3.2 mV threshold (typical)
- TRI-STATE output
- No offset nulling requirement due to on-chip AC coupling at the input
- Power fail detector with adjustable trip level senses both supplies
- Compatible with a wide range of bubble memories
- Standard 16-pin dual-in-line package

# **Block Diagram**



TRI-STATE® is a registered trademark of National Semiconductor Corp.

# **Connection Diagram**



TOP VIEW
Order Number DS1617J,
DS3617J or DS3617N
See NS Package J16A or N16A

# **Functional Pin Description**

### **ANALOG INPUTS**

Differential Analog Inputs (IN + and IN -): These are high impedance inputs for bubble memory detectors. They also provide the bias current to the detectors at a constant DC voltage. The sense-amp threshold is positive with respect to the IN + input.

Bias Voltage Input ( $V_B$ ): When an external DC voltage (between 4V and 8V) is applied to this input, the internal error amplifier will adjust the bias current sources to maintain the average common-mode voltage of IN  $^+$  and IN  $^-$  inputs at this value. This input can be connected to  $V_{DD}$  to obtain an internally set bias voltage of 7V typical. This voltage is derived on-chip from a resistor divider connected across the  $V_{DD}$  supply.

Threshold Adjust Input (V<sub>T</sub>): An externally applied DC voltage in the range of 0V to 10V at this input will set the threshold of the sense-amplifier in the 0 mV to 20 mV range. The threshold is linearly related to this voltage.

Power Fail Adjust Input (PFA): The trip voltage of 5V and 12V supplies can be set to a fraction of their nominal values by applying an external reference voltage to this input (see graph). When precise power fail detection is not required this input may be grounded to obtain a trip voltage between 35% and 65% of the nominal supply levels (i.e., 5V and 12V).

### **ANALOG OUTPUTS**

**Buffered Bubble Signal Output (BUF+):** This is the preamplifier output which is in phase with the IN<sup>+</sup> input.

It provides an amplified version of the input differential signal (X25) at a low impedance for monitoring purposes.

Internal Reference for V<sub>T</sub> (V<sub>REF</sub>): This output, when connected to V<sub>T</sub> input, provides a threshold of 3.2 mV typical. This voltage is derived on the chip from a potential divider connected across the V<sub>DD</sub> supply. When V<sub>B</sub> is also derived in the same fashion, the threshold will track the amplitude variations of the bubble signal resulting from the V<sub>DD</sub> supply variations.

### **DIGITAL INPUTS**

Unclamp Input (UC): A logic low level on this input causes clamping of the differential inputs of the comparator to a common voltage. When a logic high level is applied, the inputs are unclamped within a few nanoseconds (5 ns typ). The capacitive coupling of the preamplifier outputs to the inputs of the comparator enables referencing of the threshold to any point on the input waveform by using this input. This pin is shorted to  $V_{CC}$  or  $V_{DD}$  when the average-to-peak sensing method is used.

Strobe Input (ST): A high-to-low transition of this input causes the transfer of data from an internal latch to the output flip-flop. As long as this input is low the internal latch cannot be set by the comparator. For clamp and strobe sensing, this input can be tied to the unclamp input and used as a single UC/ST control line.

Output Disable (OD): A logic high level at this input causes the data output to go into the high impedance state (TRI-STATE).

Standby Input (SB): When the sense-amp is not in use this input can be used to reduce power consumption. A logic high level applied to this input puts the sense-amp in standby mode and TRI-STATEs the data output pin. The power fail detector circuit is not affected by this input.

### DIGITAL OUTPUTS

**Data Output (OUT):** This output is high for signals crossing the threshold and low for those below the threshold. The data on this pin is valid a short time after the negative transition of the strobe signal and will remain valid until the next negative transition of the strobe signal.

Power Fail Detect Output (NPF): This output goes low when either one or both of the supplies fall below the trip voltage. It will remain low until both of the supplies fall below a minimum level which is 4V for  $V_{DD}$  and 2.8V for  $V_{CC}$ . It is an open collector output with an internal pull-up of 5 k $\Omega$  (typical). The circuit is insensitive to transients on the supplies and will typically reject a 500 ns pulse that goes 1V below the trip voltage.

### POWER SUPPLIES

Analog Supply (Vpp): 12V.

**Digital Supply (V\_{CC}):** 5V to 12V. This supply is internally regulated to 4.5V and hence can be tied to  $V_{DD}$  for single supply operation, but a standard 5V logic supply reduces power consumption and also permits power fail detection of the 5V supply.

Absolute Maximum Rating	<b>Recommended Operating Conditions</b>				
Supply Voltages (V <sub>DD</sub> , V <sub>CC</sub> )	14V		Min	Max	Units
Input Voltages Sonse Inputs (IN +, IN -) VT input VBIAS Input (VB) Control Inputs (UN, ST, OD, SB)	14V 14V 14V 14V	V <sub>DD</sub> Supply Voltage DS1617 DS3617 V <sub>CC</sub> Supply Voltage DS1617	10.8 11.4 4.5	13 2 12.6	. v
PFA Input	5.5V	DS3617	4.75	12.6	v
Output Voltage Storage Temperature Maximum Power Dissipation* at 25°C	5.5V - 65°C to + 150°C	Temperature (T <sub>A</sub> ) DS1617 DS3617	- 55 0	125 70	°C
Cavity Package Molded Package	1635 mW 1687 mW	PFA Input Voltage VBIAS Input Voltage (VB)	0	1.5 13.2	V
Lead Temperature (Soldering, 10 seconds)	300°C	V <sub>T</sub> Input Voltage (V <sub>T</sub> ) (Threshold Adjust)	- 0.25	10	V
*Derate cavity package 10.9 mW/°C above 25°C; derate molded package 13.5 mW/°C above 25°C.		Sense Input Common Mode Voltage (V <sub>CM</sub> )	4	8	٧
		Input Bias Current (I <sub>B</sub> ) (Into IN <sup>+</sup> and IN <sup>-</sup> Inputs)	0.1	10	mA

# DC Electrical Characteristics (Notes 2 and 3)

ANALOG I V <sub>IB</sub>	NPUTS AND OUTPUTS Input Bias Voltage							
V <sub>IB</sub>	Input Bias Voltage							
	(at IN + and IN - Inputs)		Internal (Note 4)	I <sub>B</sub> in mA	Typ - 0.15	0.588 V <sub>DD</sub> + 0.01 I <sub>B</sub>		V
			External (Note 5)	l <sub>B</sub> in mA	Typ - 0.1	$V_B + 0.01 I_B$	Typ + 0.1	
ΔV <sub>IB (temp)</sub>			$I_B = 5 \text{ mA}$					
	Variation with Temperature		-55°C < T <sub>A</sub> < 125°C (DS1617)			± 10		m\
	(IN <sup>+</sup> and IN <sup>-</sup> Inputs)		0°C < T <sub>A</sub> < 70°C (DS3617)			±5		m\
lvt	Input Current for V <sub>T</sub> Input		$V_T = 0V$ to 5V			-1	- 10	μΑ
I <sub>VB</sub>	Input Current for V <sub>B</sub> Input		$V_B = 4V$ to $8V$		·	-2	- 10	μΑ
V <sub>REF</sub>	Internal Reference Voltage				0.98 Typ	0.125 V <sub>DD</sub>	1.02 Typ	V
ΔV <sub>TP (temp)</sub>	Temperature Variation of		Set by V <sub>PFA</sub> (See Graphs)					
(V <sub>CC</sub> , V <sub>DD</sub> )	Power Fail Threshold		-55°C < T <sub>A</sub> < 125°C (DS1617)			± 0.6		%
	WERNIES (OUT AURE)		0°C < T <sub>A</sub> < 70°C (DS3617)		L	± 0.2	L	%
	OUTPUTS (OUT, NPF)							
V <sub>OH</sub>	Logical "1" Output Voltage	OUT	OD = 0.8V, SB = 0.8V,		2.4	2.8		<b>\</b> ,,
		NPF	$I_{OH} = -400 \mu\text{A}$ $I_{OH} = -100 \mu\text{A}$		2.4	3.8		V
V <sub>OL</sub>	Logical "0" Output Voltage	OUT	$OD = 0.8V$ , $SB = 0.8V$ , $I_{OL} = 10 \text{ mA}$		2.4	0.4	0.5	
<b>V</b> OL	Logical o Output voltage	NPF	$V_{CC} = 4V, V_{DD} = 10V, V_{PFA} = 1.5V,$			0.4	0.5	Ιv
			$I_{OL} = 5 \text{ mA}$			0.00	0.5	
los	Output Short Circuit Current		$V_O = 0V$ , $V_{CC} = V_{DD} = Max$					
		OUT	OD = 0.8V, SB = 0.8V		- 10 - 0.5	- 20	- 50	m <i>A</i>
	<del> </del>	NPF	$V_{PFA} = 0V$			- 1	<b>– 1.5</b>	L
lop	TRI-STATE Output Current	OUT Only	OD = 2.0V, $SB = 0.8V$ or	$V_0 = 0.4V$			<b>– 100</b>	μΑ
			OD = 0.8V, SB = 2.0V	$V_0 = 4.0V$			100	<u>L'</u>
l <sub>PS</sub>	Output Sink Current on NPF		•	V <sub>CC</sub> = 0V	1	6		
	Output During Power Fail		$V_O = 0.5V$ , $V_{PFA} = 1.5V$	$V_{DD} = 4V$ $V_{CC} = 2.8V$				mA
			•	$V_{DD} = 0V$	1	6		}
CONTROL	INPUTS (UC, ST, OD, SB)			L	<b>!</b>	L		
V <sub>IH</sub>	Logical "1" Input Voltage		<del> </del>		2			V
V <sub>IL</sub>	Logical "0" Input Voltage						0.8	V
l <sub>IH</sub>	Logical "1" Input Current		V <sub>IN</sub> = 4V				20	μΑ
	Logical "0" Input Current		V <sub>IN</sub> = 0.4V				- 200	μΑ
POWER SI	UPPLY CURRENTS		<del></del>					L
DDA	Active V <sub>DD</sub> Supply Current		SB = 0.8V	<del></del>		25	45	
ICCA	Active V <sub>CC</sub> Supply Current		SB = 0.8V	<del></del>		10	20	1
I <sub>DDS</sub>	Standby V <sub>DD</sub> Supply Current		SB = 2.0V			12	25	m/
lccs	Standby V <sub>CC</sub> Supply Current		SB = 2.0V		2	4	1	

# **AC Electrical Characteristics** (Note 2)

	Parameter	<u> </u>	Conditions	Min	Тур	Max	Units
SENSE INP	UT CHARACTERISTICS						
V <sub>TH</sub>	Differential Input Threshold Voltage	V <sub>B</sub> = 7V See <i>Figur</i>	e 5 for Test Waveforms	0.97 × Typ - 0.0005	0.00213 × V <sub>T</sub>	1.03 × Typ + 0.0005	V
V <sub>TR</sub>	Threshold Adjustment Range		DS1617 DS3617	0 to 8 0 to 10	- 0.5 to 20 - 0.5 to 20		mV mV
f <sub>BW</sub>	Preamp Bandwidth	@ ±3 dB @ ±0.1 dl	$V_B = 7V, -55^{\circ}C < T_A < 125^{\circ}C$ 3, $V_B = 7V, -55^{\circ}C < T_A < 125^{\circ}C$		0.025 to 4 0.1 to 1	,	MHz
R <sub>IN</sub>	Differential Input Resistance				150		kΩ
C <sub>IN</sub>	Differential Input Capacitance				12	·	pF
ΔV <sub>TH (temp)</sub>	Threshold Variation with Temperature	V <sub>DD</sub> = 12V	-55°C <t<125°c (ds1617)<br="">0°C<t<70°c (ds3617)<="" td=""><td></td><td>± 0.1 ± 0.05</td><td></td><td>mV mV</td></t<70°c></t<125°c>		± 0.1 ± 0.05		mV mV
T <sub>PC</sub>	Effective Time Constant of Preamp AC Couplings	(From Ser Inputs) UC	se Input to Comparator		6		μS
T <sub>CL</sub>	Clamp Circuit Time Constant	,	stant Associated with the or Inputs when UC = 3V)	:	12		μS
TIMING RE	QUIREMENTS	<u> </u>	<del></del>	<u> </u>	L		
t <sub>d</sub>	Delay Time, UC or ST Input High to Sense Input High	Figure 2		50			ns
t <sub>s</sub>	Data Set-Up Time, Sense Input High to UC or ST Input Low	Figure 2		100			ns
t <sub>pwi</sub>	Minimum Input Pulse Width at Threshold	Figure 2		100			ns
t <sub>pws</sub>	Minimum Strobe Pulse Width	Figure 2		30			ns
ton	Power-Up Time from SB Low to Full Operation					100	μS
t <sub>OFF</sub>	Power-Down Time from SB High to Reduced Power					1	μS
SWITCHING	G CHARACTERISTICS						
tp	ST Input Low to Valid Data at the Output		and 3, OD = 0.8V, , R1 = 5k, R2 = 1k		30	50	ns
TRI-STATE	DELAYS FROM OD TO OUT						
t <sub>LZ</sub>	Output Low to TRI-STATE				15	35	ns
t <sub>HZ</sub>	Output High to TRI- STATE	Figures 1	and 4		15	35	ns
t <sub>ZL</sub>	Output TRI-STATE to Active Low	C <sub>L</sub> = 15 pF R2 = 1k			15	40	ns
t <sub>zH</sub>	Output TRI-STATE to Active High		·		15	40	ns

Note 1: "Absolute maximum ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" and "Recommended Operating Conditions" provide conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the supply and temperature range listed in the table of "Recommended Operating Conditions". All typical values are for  $V_{CC} = 12V$ ,  $V_{CC} = 5V$  and  $T_A = 25^{\circ}C$  unless otherwise specified.

Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise specified.

Note 4: V<sub>B</sub> pin tied to V<sub>DD</sub>.

Note 5:  $V_B$  pin connected to the external bias voltage.

# **Example Threshold Calculations**

1. Find external voltage  $V_T$  to be applied for a 5 mV typical threshold. What is this tolerance of this threshold?

$$\begin{split} &V_{TH}\,(typ) = 0.00213\,\times\,V_T = 0.005V\\ &Therefore,\,V_T = 0.005/0.00213 = \textbf{2.347V}\\ &V_{TH}\,(min) = 0.97\,\times\,0.005\,-\,0.0005 = 4.35\,\,mV\\ &V_{TH}\,(max) = 1.03\,\times\,0.005\,+\,0.0005 = 5.65\,\,mV\\ &Hence,\,V_{TH} = 5\,\pm\,0.65\,\,mV\\ &and\,\textbf{Tolerance} = \pm\,0.65\,\,mV \end{split}$$

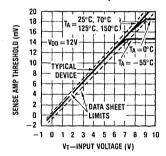
2. Find  $V_{TH}$  and its tolerance for  $V_{DD}$  = 12V when internal reference ( $V_{RFF}$ ) is used for  $V_{T}$ .

 $V_T (typ) = V_{REF} (typ) = 0.125 \times V_{DD} = 1.5V$  $V_T (min) = V_{RFF} (min) = 0.98 \times 1.5 = 1.47V$  
$$\begin{split} &V_T\,(max) = V_{REF}\,(max) = 1.02\,\times\,1.5 = 1.53V\\ &V_{TH}\,(typ) = 0.00213\,\times\,V_T\,(typ) = 3.20\;mV\\ &V_{TH}\,(min) = 0.97\,\times\,0.00213\,\times\,V_T\,(min) - 0.0005 = 2.54\;mV\\ &V_{TH}\,(max) = 1.03\,\times\,0.00213\,\times\,V_T\,(max) + 0.0005 = 3.86\;mV\\ &Hence,\,V_{TH} = 3.20\,\pm\,0.66\;mV \end{split}$$

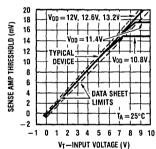
Note. Since  $V_{REF}$  is directly related to  $V_{DD}$ , the  $V_{TH}$  will follow the supply variations. But as long as the input bias voltage  $V_B$  is also derived in the same way (i.e., using a potential divider across  $V_{DD}$ ), the threshold will track the amplitude changes in the bubble detector signal resulting from the  $V_{DD}$  supply variations.

### **Performance Characteristics**

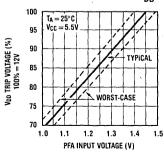
Threshold Transfer Function at Various Temperatures



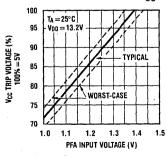
Threshold Transfer Function at Various Supply Voltages



Power Fail Trip Voltage Transfer Function for V<sub>DD</sub>



### Power Fail Trip Voltage Transfer Function for V<sub>CC</sub>



# **AC Test Circuit and Switching Time Waveforms**

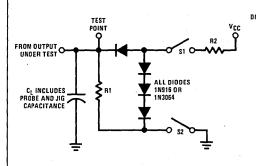


FIGURE 1. Output Load Circuit

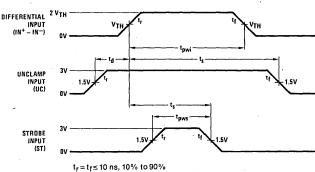


FIGURE 2. Delay, Set-Up and Hold Times

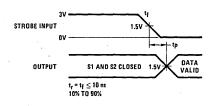
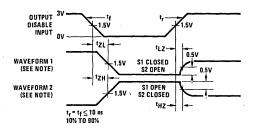
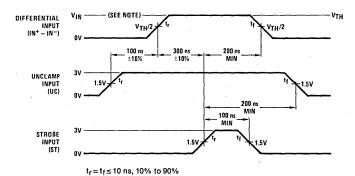


FIGURE 3. Propagation Delay from Strobe Input to Output



Note. Waveform 1 shows the output with internal conditions such that the output is low except when disabled by the output disable input. Waveform 2 shows the output with internal conditions such that the output is high except when disabled by the output disable input.

FIGURE 4. Propagation Delay from Output Disable to Output

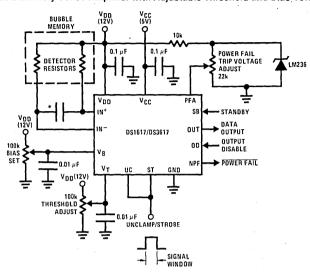


Note. To determine the sense amplifier threshold, the input signal amplitude,  $V_{IN}$ , is varied around the set threshold value,  $V_{TH}$ , while monitoring the OUT pin on a scope. When  $V_{IN}$  is close to the threshold, the output will switch between Logic 0 and Logic 1 due to the noise on the input signal. The mid value of the threshold can be determined by adjusting  $V_{IN}$  to obtain equal brightness of high (VOH) and low (VOL) level output traces on the scope. In the above set-up, the signal is strobed after a 300 ns delay to allow for any overshoot or transients to settle. This method results in accurate threshold measurement that is relatively independent of input signal rise time. But due to AC coupling of the preamp, with an effective time constant of 6  $\mu s$ , the signal at the input of the comparator droops by 5% in 300 ns, which has to be accounted for. Hence,  $V_{TH} = V_{IN} \times 0.95$ .

FIGURE 5. Sense Input Threshold Measurement

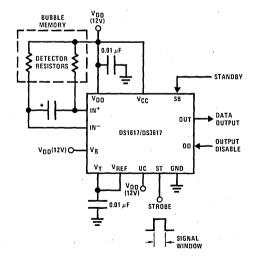
# **Typical Applications**

### **Bubble Memory Sense Amplifier with Adjustable Threshold and Bias Voltage**



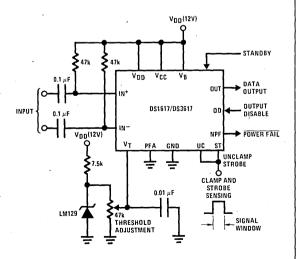
Note. The control inputs are set up for clamp-strobe or peak-to-peak sensing \*Optional band limiting capacitor

# Bubble Memory Sense Amplifier with Internally Set Threshold (3 mV typ) and Input Bias Voltage (7V typ)



Note. The control inputs are set up for average-to-peak sensing \*Optional band limiting capacitor

# A General Purpose Precision Sense Amplifier with the Threshold Controlled by an External Reference



# **Memory Support**

# DS1628/DS3628 Octal TRI-STATE® MOS Drivers

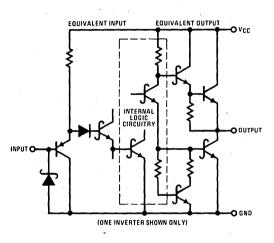
# **General Description**

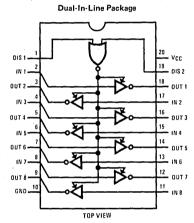
The DS1628/DS3628 are octal Schottky memory drivers with TRI-STATE® outputs designed to drive high capacitive loads associated with MOS memory systems. The drivers' output (VOH) is specified at 3.4 V to provide additional noise immunity required by MOS inputs. A PNP input structure is employed to minimize input currents. The circuit employs Schottky-clamped transistors for high speed. A NOR gate of two inputs, DIS1 and DIS2, controls the TRI-STATE mode.

### **Features**

- High speed capabilities
  - typ 5 ns driving 50 pF & 8 ns driving 500 pF
- TRI-STATE outputs
- High VOH (3.4 V min)
- High density
  - eight drivers and two disable controls for TRI-STATE in a 20-pin package
- PNP inputs reduce DC loading on bus lines
- Glitch-free power up/down

# **Schematic and Connection Diagrams**





Order Number DS1628J, DS3628J, DS3628N See NS Package J20A or N20A

# **Truth Table**

Disabl	Disable Input		Outroit
DIS 1	DIS 2	Input	Output
Н	Н	x	Ζ,
н	X	<b>X</b>	z
) x	Н	\ x	z
L	· L	} н	L
L	L	L	н

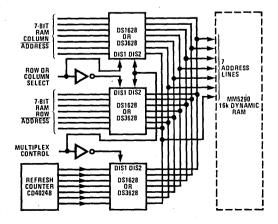
H = high level

L = low level

X = don't care

Z = high impedance (off)

# **Typical Application**



### Absolute Maximum Ratings (Note 1) **Operating Conditions** UNITS MIN MAX Supply Voltage 7.0V 4.5 5.5 ٧ Supply Voltage (V<sub>CC</sub>) Logical "1" Input Voltage 7.0V Temperature (TA) Logical "0" Input Voltage -1.5V °C DS1628 -55 +125 -65°C to +150°C Storage Temperature Range °c DS3628 0 +70 Maximum Power Dissipation\* at 25°C Cavity Package 1667 mW Molded Package 1832 mW

300°C

Lead Temperature (Soldering, 10 seconds)

# Electrical Characteristics (Notes 2 and 3)

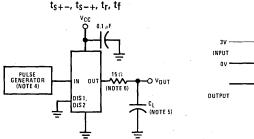
	PARAMETER		CONDITION	IS	MIN	TYP	MAX	UNITS
V <sub>IN(1)</sub>	Logical "1" Input Voltage				2.0	[		V
VIN(0)	Logical "0" Input Voltage						0.8	V
I <sub>IN(1)</sub>	Logical "1" Input Current	V <sub>CC</sub> = 5.5 V	V <sub>IN</sub> = 5.5 V			0.1	40	μΑ
<sup>1</sup> IN(0)	Logical "0" Input Current	V <sub>CC</sub> = 5.5 V	V <sub>IN</sub> = 0.5V			-180	-400	μА
VCLAMP	Input Clamp Voltage	V <sub>CC</sub> = 4.5V	I <sub>IN</sub> = -18mA			-0.7	-1.2	V
.,	Logical "1" Output Voltage	1 - 451	10	DS1628	3.4	4.3		V
Vон	(No Load)	VCC = 4.5 V	$I_{OH} = -10\mu A$	DS3628	3.5	4.3		V
.,	Logical "0" Output Voltage	V - 45V	1	DS1628 .		0.25	0.4	٧
VOL	(No Load)	V <sub>CC</sub> = 4.5V	IOL - IOMA	DS3628		0.25	0.35	٧
.,	Logical "1" Output Voltage	V 4 5 V	C = 4.5V I <sub>OH</sub> = -1.0mA	DS1628	2.5	3.9		<b>V</b>
Voн	(With Load)	VCC - 4.5 V	10H1.0MA	DS3628	2.7	3.9		V
VOL	Logical "0" Output Voltage (With Load)	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 20mA	DS1628/DS3628		0.35	0.5	V
l <sub>ID</sub>	Logical "1" Drive Current	V <sub>CC</sub> = 4.5V	V <sub>OUT</sub> = 0V	(Note 6)		-150		mA
lop	Logical "0" Drive Current	V <sub>CC</sub> = 4.5V	V <sub>OUT</sub> = 4.5 V	(Note 6)	Ţ	150		mA
Hi-Z	TRI-STATE Output Current	V <sub>OUT</sub> = 0.4\	to 2.4 V DIS1	or DIS2 = 2.0 V	-40	0.1	40	μА
			One DIS Input = All other Inputs =	3.0 V = X, Outputs at Hi-Z		90	120	mΑ
Icc	CC Power Supply Current V <sub>CC</sub> = 5.	V <sub>CC</sub> = 5.5 V	DIS1, DIS2 = 0\ Outputs on	/, others = 3 V		70	100	mA
	•		All Inputs = 0 V, Outputs o			25	. 50	mΑ

# Switching Characteristics (V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C) (Note 6)

	PARAMETER	cc	CONDITIONS		TYP	MAX	UNITS
	Chavena Dalay Namaiya Edan	75imum 1)	C <sub>L</sub> ≃ 50pF		4.0	5.0	ns
t <sub>S+-</sub>	Storage Delay Negative Edge	(Figure 1)	C <sub>L</sub> = 500pF		6.5	8.0	ns
	Storage Delay Positive Edge	(Figure 1)	C <sub>L</sub> = 50pF		4.2	5.0	ns
ts-+		(Figure 1)	C <sub>L</sub> = 500pF		6.5	8.0	ns
	Fall Time	/C:= 1\	CL = 50pF		4.2	6.0	ns
t <sub>F</sub>	rail little	(Figure 1)	C <sub>L</sub> = 500pF		19	22	ns
	Dia Time	(Figure 1)	C <sub>L</sub> = 50pF		5.2	7.0	ns
<sup>t</sup> R	Rise Time		C <sub>L</sub> = 500pF		20	24	ns
<sup>t</sup> ZL	Delay from Disable Input to Logical "0" Level (from High Impedance State)	CL = 50pF to GND	RL ≈ 2kΩ to VCC (Figure 2)		19	25	ns
<sup>t</sup> ZH	Delay from Disable Input to Logical "1" Level (from High Impedance State)	CL = 50pF to GND	$R_L = 2k\Omega$ to GND (Figure 2)		13	20	ns
<sup>t</sup> LZ	Delay from Disable Input to High Impedance State (from Logical "O" Level)	CL = 50pF to GND	R <sub>L</sub> = $400\Omega$ to V <sub>CC</sub> (Figure 3)	,	18	25	ns
tHZ	Delay from Disable Input to High Impedance State (from Logical "1" Level)	CL = 50pF to GND	R <sub>L</sub> = $400\Omega$ to GND (Figure 3)		8.5	15	ns

<sup>\*</sup>Derate cavity package 11.1 mW/°C above 25°C; derate molded package 14.7 mW/°C above 25°C.

# **AC Test Circuits and Switching Time Waveforms**



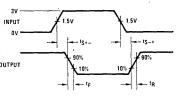
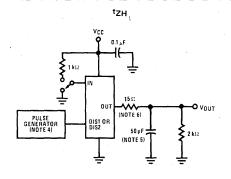
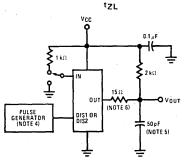
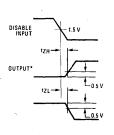


FIGURE 1

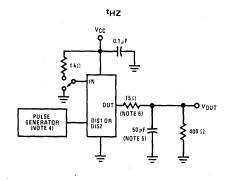


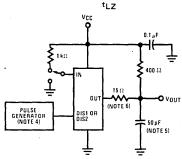




\*ANY ONE OF EIGHT OUTPUTS

FIGURE 2





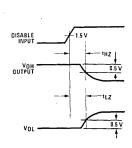


FIGURE 3

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS1628 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS3628. All typical values are for  $T_{A} = 25^{\circ}$ C and  $V_{CC} = 5$  V.

Note 3: All currents into device pins shown as positive; all currents out of device pins shown as negative; all voltages references to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: The pulse generator has the following characteristics:  $Z_{OUT} = 50 \Omega$  and PRR  $\leq$  1 MHz. Rise and fall times between 10% and 90% points  $\leq$  5 ns.

Note 5: CL includes probe and jig capacitance.

Note 6: When measuring output drive current and switching response for the DS1628 and DS3628 a 15  $\Omega$  resistor should be placed in series with each output.

# DS1644/DS3644, DS1674/DS3674 Quad TTL to MOS **Clock Drivers**

# **General Description**

The DS1644/DS3644 and DS1674/DS3674 are quad bipolar-to-MOS clock drivers with TTL compatible inputs. They are designed to provide high output current and voltage capabilities necessary for optimum driving of high capacitance N-channel MOS memory systems.

The device features two common enable inputs, a refresh input, and a clock control input for simplified system designs. The circuit was designed for driving highly capacitive loads at high speeds and uses Schottkyclamped transistors. PNP transistors are used on all inputs thereby minimizing input loading.

The circuit may be connected to provide a 12V clock output amplitude as required by 4k RAMs or a 5V clock output amplitude as required by 16k RAMs.

The DS1644/DS3644 contains a  $10\Omega$  resistor in series with each output to dampen the transients caused by the fast-switching output, while the DS1674/DS3674

**Memory Support** 

# **Features**

- TTL compatible inputs
- 12V clock or 5V clock driver

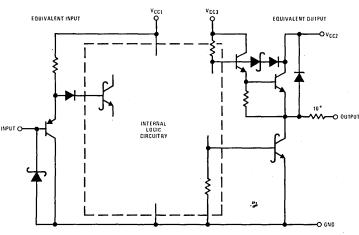
without an external damping resistor.

Operates from standard bipolar and MOS supplies

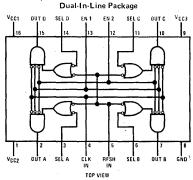
has a direct, low impedance output for use with or

- PNP inputs minimize loading
- High voltage/current outputs
- Input and output clamping diodes
- Control logic optimized for use with MOS memory systems
- Pin and function compatible with MC3460 and 3235
- Built-in damping resistors (DS1644/DS3644)

# Schematic and Connection Diagrams



\* DS1644/DS3644 only



Order Number DS3644J, DS3674J, DS3644N or DS3674N See NS Package J16A or N16A

Absolute Maximum Ratings (Note 1)		Operating Condition			
			MIN	MAX	UNITS
Supply Voltage		Supply Voltage			
V <sub>CC1</sub>	. 7V	V <sub>CC1</sub>			
V <sub>CC2</sub>	13.5V	DS1644, DS1674	4.5	5.5	V
V <sub>CC3</sub>	16V	DS3644, DS3674	4.75	5.25	V
Input Voltage	-1.0V to +7V	V <sub>CC2</sub>			
Output Voltage	-1.0V to +16V	DS1644, DS1674	4.5	13.2	V
Storage Temperature Range	–65°C to +150°C	DS3644, DS3674	4.75	12.6	V
Maximum Power Dissipation* at 25°C		V <sub>CC3</sub>			
Cavity Package	1509 mW	DS1644, DS1674	V <sub>CC2</sub>	16.5	V
Molded Package	1476 mW	DS3644, DS3674	V <sub>CC2</sub>	15.75	V
Lead Temperature (Soldering, 10 seconds)	300°C	Temperature, T <sub>A</sub>			
*Derate cavity package 10.1 mW/° C above 25	C; derate molded	DS1644, DS1674	-55	+125	°C
package 11.8 mW/° C above 25° C.		DS3644, DS3674	0	+70	°C

### **Electrical Characteristics**

5V operation, ( $V_{CC1} = V_{CC2} = 5V$ ,  $V_{CC3} = 12V$ ); 12V operation, ( $V_{CC1} = 5V$ ,  $V_{CC2} = 12V$ ,  $V_{CC3} = V_{CC2} + (3V \pm 10\%)$ ); DS1644, DS1674,  $\pm 10\%$  power supply tolerances; DS3644, DS3674,  $\pm 5\%$  power supply tolerances, unless otherwise noted. (Notes 2, 3 and 4).

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
VIН	Logical "1" Input Voltage			2			V
VIL	Logical "0" Input Voltage					0.8	V
lін	Logical "1" Input Current	V = E EV	Select Inputs		0.01	10	μА
		V <sub>IN</sub> = 5.5V	All Other Inputs		0.04	40	μΑ
ելը	Logical "0" Input Current	V··· = 0.4V	Select Inputs		-40	-250	μΑ
		V <sub>IN</sub> = 0.4V	All Other Inputs		<b>−</b> 0.16	-1.0	mA
VCD	Input Clamp Voltage	I <sub>I</sub> = -12 mA		-0.8	-1.5		
VOH	Logical "1" Output Voltage	IOH = -1 mA, VIL =	V <sub>CC2</sub> -0.5	V <sub>CC2</sub> -0.2		V	
VOL	Logical "0" Output Voltage	I <sub>OL</sub> = 5 mA, V <sub>IH</sub> = 2		0.3	0.5	V	
Voc	Output Clamp Voltage	IOC = 5 mA, VIL = 0.	8V		V <sub>CC2</sub> +0.8	V <sub>CC2</sub> +1.5	V
Іссн	Supply Current Output High			,			
	<sup>1</sup> CC1		V <sub>CC1</sub> = Max		18	27	mA
	I <sub>CC2</sub>	All Inputs VIN = 0V	12V Operation		-2	-4	mA
	ICC3	Outputs Open	12 V Operation		2	4	mA
	I <sub>CC2</sub>		EV Onessiss		-8	-16	mA
	1CC3		5V Operation		8	16	mA
ICCL	Supply Currents Outputs Low						
	ICC1	All Inputs V = EV	V <sub>CC1</sub> = 5.25V		25	40	mA
	ICC2	All Inputs V <sub>IN</sub> = 5V Outputs Open	V <sub>CC2</sub> = 12.6V			3	mA
	ICC3	Outputs Open	V <sub>CC3</sub> = 15.75V		16	25	mA

# Switching Characteristics T<sub>A</sub> = 25°C unless otherwise noted, (Note 4), (Figures 1, 2, 3 and 4)

PARAMETER		CON	CONDITIONS		TYP	MAX	UNITS
t <sub>s+</sub> _	Storage Delay Negative Edge	R <sub>D</sub> = 10 Ω	C <sub>L</sub> = 100 pF		8	11	ns
		110 - 10 32	C <sub>L</sub> = 400 pF		12	16	ns
t <sub>s-+</sub>	Storage Delay Positive Edge	D 10.0	CL = 100 pF		10	13	ns
	*	$R_D = 10 \Omega$	C <sub>L</sub> = 400 pF		. 13	16	ns
tF	Fall Time RD =	D 10 O	CL = 100 pF		9	16	ns
		$R_D = 10 \Omega$	C <sub>L</sub> = 400 pF		17	24	ns
tR	Rise Time	R <sub>D</sub> = 10 Ω	C <sub>L</sub> = 100 pF	1	8	12	ns
	•	ND - 1032	C <sub>L</sub> = 400 pF		13	19	ns
t <sub>pd</sub> 0	Propagation Delay to a	Po = 10.0	C <sub>L</sub> = 100 pF		17	27	ns
	Logical "0"	$R_D = 10 \Omega$	C <sub>L</sub> = 400 pF		29	40	ns
t <sub>pd1</sub>	Propagation Delay to a	R <sub>D</sub> = 10 Ω	C <sub>L</sub> = 100 pF		18	25	ns
	Logical "1"	MD - 10.75	C <sub>L</sub> = 400 pF		26	35	ns

### **Notes**

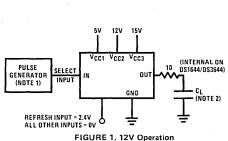
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DS1644, DS1674 and across the  $0^{\circ}$  C to +70° C range for the DS3644, DS3674. All typicals are given for T<sub>A</sub> = 25° C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: For AC measurements, a  $10\Omega$  resistor must be placed in series with the output of the DS1674/DS3674. This resistor is internal to the DS1644/DS3644 and need not be added.

# **AC Test Circuits and Switching Time Waveforms**



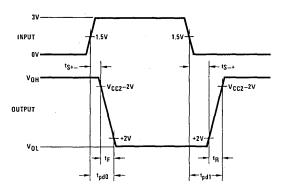


FIGURE 2. 12V Operation

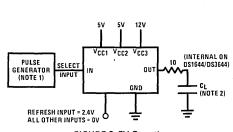


FIGURE 3. 5V Operation

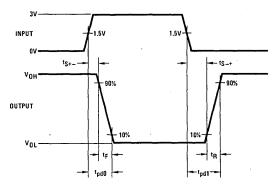


FIGURE 4. 5V Operation

Note 1: The pulse generator has the following characteristics. PPR = 1 MHz,  $t_R \le 10$  ns,  $z_{OUT} = 50\Omega$ .

Note 2: CL includes probe and jig capacitance.

### **Truth Table**

	INPUT							
ENABLE 1	ENABLE 2	SELECT INPUT	CLOCK INPUT	REFRESH INPUT	OUTPUT			
1	х	х	×	х	0			
x	1	х	×	×	0			
X	X	Χ.	1	×	0			
x	Х	1	X	1	0			
0	0	0	Ò	×	1			
0	0	Х	0	.0	1			



# **Memory Support**

# DS1645/DS3645, DS1675/DS3675 Hex TRI-STATE® TTL to MOS Latches/Drivers

# **General Description**

The DS1645/DS3645 and DS1675/DS3675 are hex MOS latches/drivers with outputs designed to drive large capacitive loads up to 500 pF associated with MOS memory systems. PNP input transistors are used to reduce input currents, allowing the large fan-out to these drivers needed in memory systems. The circuit has Schottky-clamped transistor logic for minimum propagation delay, and TRI-STATE® outputs which allow bus operation.

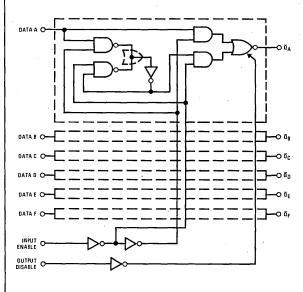
The DS1645/DS3645 has a 15  $\Omega$  resistor in series with the outputs to dampen transients caused by the fast switching output circuit. The DS1675/DS3675 has a direct, low impedance output for use with or without an external resistor.

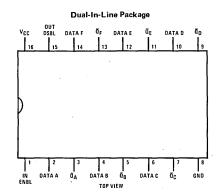
The circuit employs a fall-through-latch which captures the data in parallel with the output, thereby eliminating the delay normally encountered in other latch circuits. The DS1645/DS3645 and DS1675/DS3675 may be used for input address lines or input/output data lines of a MOS memory system.

### **Features**

- TTL compatible inputs
- PNP inputs minimize loading
- Capacitance-driving outputs
- TRI-STATE outputs
- Built-in damping resistor (DS1645/DS3645)

# **Logic and Connection Diagrams**





Order Number DS1645J, DS1675J, DS3645J, DS3675J, DS3645N or DS3675N See NS Package J16A or N16A

### **Truth Table**

INPUT ENABLE	OUTPUT DISABLE	DATA	OUTPUT	OPERATION
1	0	1	0 -	Data Feed-Through
1	0	0	1	Data Feed-Through
. 0	0	, <b>x</b>	Q	Latched to Data Present when Enable Went Low
×	1	×	Hi-Z	High Impedance Output

X = Don't care

Hi-Z = TRI-STATE mode

UNITS V

# Absolute Maximum Ratings (Note 1)

# **Operating Conditions**

			MIN	MAX
Supply Voltage, VCC	7V	Supply Voltage (VCC)	4.5	5.5
Logical "1" Input Voltage Logical "0" Input Voltage Storage Temperature Range Maximum Power Dissipation* at 25°C	7V -1.5V -65°C to +150°C	Temperature (T <sub>A</sub> ) DS1645, DS1675 DS3645, DS3675	-55 0	+125 +70
Cavity Package Molded Package Lead Temperature (Soldering, 10 seconds)	1433 mW 1362 mW 300°C			

<sup>\*</sup>Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.9 mW/°C above 25°C.

# Electrical Characteristics (Notes 2 and 3)

	PARAMETER		CONDITION	S	MIN	TYP	MAX	UNITS
VIN(1)	Logical "1" Input Voltage				2.0			V
V <sub>IN(0)</sub>	Logical "0" Input Voltage						0.8	V
UN(1)	Logical "1" Input Current	V <sub>IN</sub> = 5.5V Enable Inputs			0.1	40	μА	
_		V <sub>CC</sub> = 5.5V	Data Inputs	. •		0.2	80	μΑ
IN(0)	Logical "0" Input Current	V <sub>IN</sub> = 0.5V	Enable Inputs			-50	-250	μΑ
		V <sub>CC</sub> = 5.5V	Data Inputs			-100	500	μΑ
VCLAMP	Input Clamp Voltage	V <sub>CC</sub> = 4.5V,	IIN = -18 mA			-0.75	-1.2	V
VOH Logical "1" Output Voltage	DS1645, DS1675		2.7	3.6		V		
	(No Load)	$V_{CC} = 4.5V, I_{OH} = -10 \mu A$		DS3645, DS3675	2.8	3.6		٧
VOL	Logical "O" Output Voltage	V <sub>CC</sub> = 4.5V, I <sub>OL</sub> = 10 μA DS1645, DS1675 DS3645, DS3675			0.25	0.4	V	
	(No Load)				0.25	0.35	. V	
VOH Logical "1" Output (With Load)	Logical "1" Output Voltage (With Load)	VCC = 4.5V, IOH = -1.0 mA		2.4	3.5		V	
				2.5	3.5		V	
		DS3645	2.6	3.5				
				DS3675	2.7	3.5		V
	Logical "0" Output Voltage	V <sub>CC</sub> = 4.5V, I <sub>OL</sub> = 20 mA DS1645 DS1675 DS3645			0.6	1.1	V	
	(With Load)				0.4	0.5	V	
					0.6	1.0	V	
		·		DS3675		0.4	0.5	V
۱۱D	Logical "1" Drive Current	V <sub>CC</sub> = 4.5V, V <sub>OUT</sub> = 0V, (Note 4)				-250		mA
lop	Logical "0" Drive Current	V <sub>CC</sub> = 4.5V, V <sub>OUT</sub> = 4.5V, (Note 4)				150		mA
IHZ	TRI-STATE Output Current	VOUT = 0.4V to 2.4V, Output Disable = 2.0V		-40		40	μΑ	
ICC Power St	Power Supply Current	V	Output Disable All Other Input			60	100	mA
		V <sub>CC</sub> = 5.5V	Input Enable = All Other Input			40	80	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

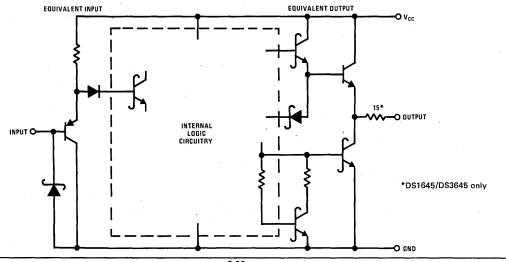
Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS1645 and DS1675 and across the 0°C to  $+70^{\circ}$ C range for the DS3645 and DS3675. All typical values are for  $T_{A} = 25^{\circ}$ C and  $V_{CC} = 5V$ .

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: When measuring output drive current and switching response for the DS1675 and DS3675 a 15 ohm resistor should be placed in series with each output. This resistor is internal to the DS1645/DS3645, and need not be added.

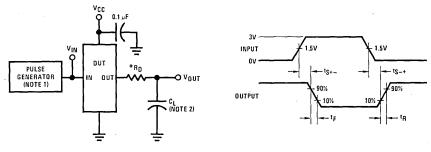
PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS
t <sub>S+</sub> _	Storage Delay Negative Edge	(Figure 1)	C <sub>L</sub> = 50 pF C <sub>I</sub> = 500 pF		4.5 8	7	ns ns
ts-+	Storage Delay Positive Edge	(Figure 1)	C <sub>L</sub> = 50 pF C <sub>L</sub> = 500 pF		6	8	ns
tF	Fall Time	(Figure 1)	CL = 500 pF CL = 500 pF		5 21	8 35	ns
tR	Rise Time	(Figure 1)	C <sub>L</sub> = 50 pF C <sub>L</sub> = 500 pF		6 22	9 35	ns
tSET-UP	Set-Up Time on Data Input Before Input Enables Goes Low			10	0		ns
tHOLD	Hold Time on Data Input After Input Enable Goes Low			15	5		ns
tw	Minimum Width of Enable Pulse to Latch Data			20	5		ns
<sup>†</sup> ZL	Delay from Disable Input to Logical "0" Level (from High Impedance State)	C <sub>L</sub> = 50 pF,	$R_L = 2 k\Omega$ to $V_{CC}$ , (Figure 2)		10	15	ns
<sup>t</sup> ZH	Delay from Disable Input to Logical "1" Level (from High Impedance State)	CL.= 50 pF,	$R_L = 2 k\Omega$ to Ground, (Figure 2)		10	15	ns
tLZ	Delay from Disable Input to High Impedance State (from Logical "0" Level)	C <sub>L</sub> = 50 pF,	$R_L = 400\Omega$ to $V_{CC}$ , (Figure 3)		. 16	25	ns
tHZ	Delay from Disable Input to High Impedance State (from Logical "1" Level)	CL = 50 pF,	$R_L = 400\Omega$ to Ground, (Figure 3)		16	25	ns

# Schematic Diagram



# AC Test Circuits and Switching Time Waveforms

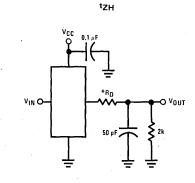
tS+-, tS-+, tR, tF



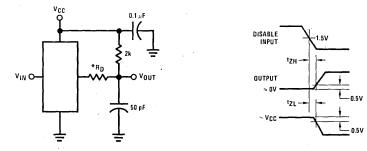
Note 1: The pulse generator has the following characteristics: Z $_{OUT}$  = 50  $\Omega$  and PRR  $\leq$  1 MHz. Rise and fall times between 10% and 90% points  $\leq$  5 ns.

Note 2: C<sub>L</sub> includes probe and jig capacitance.

FIGURE 1



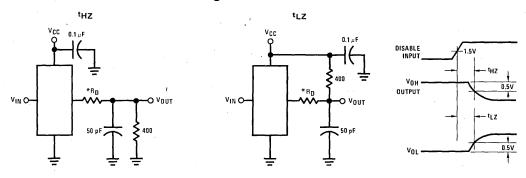
tzL



\*Internal on DS1645 and DS3645

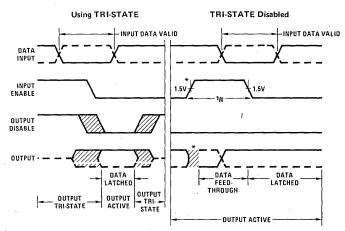
FIGURE 2

# AC Test Circuits and Switching Time Waveforms (Continued)



\*Internal on DS1645 and DS3645 FIGURE 3

# **Operating Waveforms**



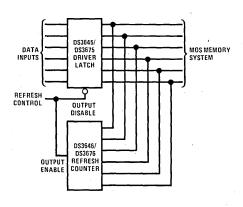
<sup>\*</sup>When the Input Enable makes a positive transition the output will be indeterminate for a short duration.

The positive transition of the Input Enable normally occurs during a don't-care timing state at the output.

# **Typical Applications**

The DS3645 and DS3675 latch/driver has TRI-STATE outputs, which allows the outputs to be tied with those of another TRI-STATE driver, such as the DS3646 and

DS3676 refresh counter. The DS3645 and DS3675 can be disabled while the alternate driver controls the address lines into the memory system.





# **Memory Support**

# DS1647/DS3647, DS1677/DS3677, DS16147/DS36147, DS16177/DS36177 Quad TRI-STATE® MOS Memory I/O Registers

# **General Description**

The DS1647/DS3647 series are 4-bit I/O buffer registers intended for use in MOS memory systems. The circuits employ a fall-through latch for data storage. This method of latching captures the data in parallel with the output, thus eliminating the delays encountered in other designs. The circuits use Schottky-clamped transistor logic for minimum propagation delay and employ PNP input transistors-so that input currents are low, allowing large fan-out to these circuits needed in a memory system.

Two pins per bit are provided, and data transfer is bidirectional so that the register can handle both input and output data. The direction of data flow is controlled through the input enables. The latch control, when taken low, will cause the register to hold the data present at that time and display it at the outputs. Data can be latched into the register independent of the output disables or EXPANSION input. Either or both of the outputs may be taken to the high-impedance state with the output disables. The EXPANSION pin disables both outputs to facilitate multiplexing with other I/O registers on the same data lines.

The "B" port outputs in the DS16147/DS36147 and DS16177/DS36177 are open collectors, and in the

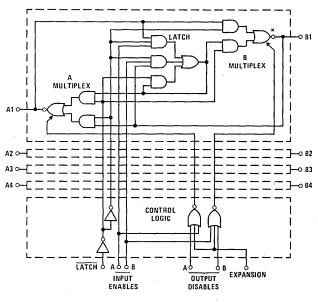
DS1647/DS3647 and DS1677/DS3677 they are TRI-STATE. The "B" port outputs are also designed for use in bus organized data transmission systems and can sink 80 mA and source –5.2 mA. The "A" port outputs in all four types are TRI-STATE.

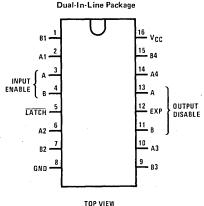
Data going from port "A" to port "B" is inverted in the DS1647/DS3647 and DS16147/DS36147 and is not inverted in the DS1677/DS3677 and DS16177/DS36177. Data going from port "B" to port "A" is inverted in all four types.

# **Features**

- PNP inputs minimize loading
- Fall-through latch design
- Propagation delay of only 15 ns
- TRI-STATE outputs
- EXPANSION control
- Bi-directional data flow
- TTL compatible
- Transmission line driver output

# Logic and Connection Diagrams





Order Number DS1647D, DS3647D, DS1677D, DS3677D, DS16147D, DS36147D, DS16177D, DS36177D, DS36177D, DS3647N, DS3647N, DS36177N

See NS Package D16A or N16A

<sup>\*</sup>Inverting DS1647/DS3647 and DS16147/DS36147 only

Absolute Maximum Ratio	Operating Conditions					
			MIN	MAX	UNITS	
Supply Voltage	7V	Supply Voltage (VCC)	4.5	5.5	V	
Input Voltage	-1.5V to +7V	Temperature (T <sub>△</sub> )				
Storage Temperature Range	-65°C to +150°C	DS1647, DS1677, DS16147,	-55	+125	°C	
Maximum Power Dissipation* at 25°C	DS16177					
Cavity Package	1509 mW	DS3647, DS3677, DS36147,	0	+70	°c	
Molded Package	1476 mW	DS36177	·	.,,	Ū	
Lead Temperature (Soldering, 10 seconds)	300° C	2330177				
*Derate cavity package 10.1 mW/° C above 25 package 11.8 mW/° C above 25° C.	°C; derate molded	•				

Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
VIN(1)	Logic "1" Input Voltage			2.0			٧
VIN(0)	Logic "0" Input Voltage					0.8	V
IN(1) Logic "1" Input Current		·	Latch, Disable Inputs		0.1	40	μΑ
	V <sub>CC</sub> = 5.5V, V <sub>IN</sub> = 5.5V	Expansion		0.2	80	μΑ	
	"	A Ports, B Ports		0.2	100	μΑ	
		Enable Inputs		0.4	200	μΑ	
IIN(0) Logic "0" Input Current	Latch, Disable Inp			-25	-250	μΑ	
		Vcc = 5.5V, V <sub>IN</sub> = 0.5V	Expansion		-50	-500	μΑ
		VCC = 5.5V, VIN = 0.5V	A Ports, B Ports		-50	-500	μΑ
	Enable, Inputs			-0.1	-1.25	mA	
<sup>V</sup> CLAMP	Input Clamp Voltage	VCC = 4.5V, I <sub>IN</sub> = -18 mA			-0.6	-1.2	
VOL(A)	Logic "0" Output Voltage A Ports	V <sub>CC</sub> = 4.5V, I <sub>OL</sub> = 20 mA			0.4	0.5	٧
VOL(B) Logic "0" Output Voltage B Ports	$V_{CC} = 4.5V$ $I_{OL} = 30 \text{ mA}$ $I_{OL} = 50 \text{ mA}$	IOL = 30 mA		0.3	0.4	V	
		IOL = 50 mA		0.4	0.5	V	
VOH(A)	OH(A) Logic "1" Output Voltage	$I_{OH} = -1 \text{ mA}$ $V_{CC} = 5V$ $V_{CC} = 4.5V$	V <sub>CC</sub> = 5V	3.0	3.4		V
	A Ports		V <sub>CC</sub> = 4.5V	2.5	3.4		V
VOH(B)	(B) Logic "1" Output Voltage	V <sub>CC</sub> = 5V		2.9	3.3		V
,,	B Ports	IOH = -5.2 mA, (Note 4)	V <sub>CC</sub> = 4.5V	2.4	3.3		V
los(A)	Output Short-Circuit Current A Port	V <sub>CC</sub> = 4.5V to 5.5V, V <sub>OUT</sub> = 0V, (Note 5)		-30	-50	-100	mA
IOS(B)	Output Short-Circuit Current B Port	V <sub>CC</sub> = 4.5V to 5.5V, V <sub>OUT</sub> = 0V, (Notes 4 and 5)		-30	-60	-100	mA
Icc	Power Supply Current	Exp = 3V, A Ports = 0V,	DS1647, DS16147		100	110	mA
200		B Ports Open, All Other Pins = 0V	DS3647, DS36147		100	140	mA
		Enable A, Latch = 3V, A Ports =	DS1647, DS16147		70	80	mA
	0V, B Ports Open, All Other Pins = 0V	DS3647, DS36147		70	105	mA	
	,	Exp = 3V, A Ports = 0V,	DS1677, DS16177		105	115	mA
		B Ports Open, All Other Pins = 0V	DS3677, DS36177		105	145	mA
		Enable A, Latch, A Ports = 3V,	DS1677, DS16177		75	85	mA
·		B Ports Open, All Other Pins = 0V	DS3677, DS36177		75	110	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DS1647, DS1677, DS16147, DS16177 and across the 0°C to +70°C range for the DS3647, DS3677, DS36147, DS36177. All typicals are given for VCC = 5V and TA = 25°C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted.

Note 4: Not applicable to DS16147/DS36147 or DS16177/DS36177.

Note 5: Only one output at a time should be shorted.

# Switching Characteristics ( $V_{CC} = 5V, T_A = 25^{\circ}C$ )

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
DATA	TRANSFER B PORT TO A PORT, A			<del>,</del>	·	<del> </del>
t <sub>pd</sub> 0	Propagation Delay to a Logic "O"	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 280 Ω, (Figures 1 and 4)		7.5	15	ns
<sup>t</sup> pd1	Propagation Delay to a Logic "1"	$C_L = 50 \text{ pF}, R_L = 280 \Omega,$ (Figures 1 and 4)		6.0	12	ns
A POR	T CONTROL FROM OUTPUT DISA	BLE A INPUT, ALL DEVICES	<del></del>	<del></del>		
tLZ	Delay to High Impedance from Logic "O"	(Figures 1 and 5)		13	20	ns
tHZ	Delay to High Impedance from Logic "1"	(Figures 1 and 6)		14	20	ns
†ZL	Delay to Logic "0" from High Impedance	(Figures 1 and 7)		10	15	ns
tΖΗ	Delay to Logic "1" from High Impedance	(Figures 1 and 8)		25	35	ns
DATA	TRANSFER A PORT TO B PORT, D	S1647/DS3647				
tpd0	Propagation Delay to a Logic "O"	$C_L = 50 \text{ pF}, R_L = 100 \Omega,$ (Figures 2 and 4)		6.5	12	ns
<sup>t</sup> pd1	Propagation Delay to a Logic "1"	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 100 $\Omega$ , (Figures 2 and 4)		8.0	15	ns
DATA	TRANSFER A PORT TO B PORT, D	S1677/DS3677				
t <sub>pd</sub> 0	Propagation Delay to a Logic "O"	$C_L = 50 \text{ pF}, R_L = 100 \Omega,$ (Figures 2 and 4)		12.5	20	ns
t <sub>pd1</sub>	Propagation Delay to a Logic "1"	$C_L = 50 \text{ pF}, R_L = 100 \Omega,$ (Figures 2 and 4)		8.5	15	ns
DATA	TRANSFER A PORT TO B PORT DS	S16147/DS36147				
t <sub>pd</sub> 0	Propagation Delay to a Logic "0"	C <sub>L</sub> = 50 pF, (Figures 3 and 4)		18	25	ns
t <sub>pd1</sub>	Propagation Delay to a Logic "1"	C <sub>1</sub> = 50 pF, (Figures 3 and 4)	1	7.0	15	ns
DATA	TRANSFER A PORT TO B PORT, D	S16177/DS36177	<u> </u>	<del></del>	·	
tpd0	Propagation Delay to a Logic "0"	C <sub>L</sub> = 50 pF, (Figures 3 and 4)		13.5	21	ns
t <sub>pd1</sub>	Propagation Delay to a Logic "1"	C <sub>L</sub> = 50 pF, (Figures 3 and 4)	<del>                                     </del>	18	25	ns
	T CONTROL FROM OUTPUT DISAE		S1677/DS36	. L		
tLZ	Delay to High Impedance from Logic "0"	(Figures 2 and 5)		15	25	ns
tНZ	Delay to High Impedance from Logic "1"	(Figures 2 and 6)		14	20	ns
†ZL	Delay to Logic "0" from High Impedance	(Figures 2 and 7)		10	16	ns
<sup>t</sup> ZH	Delay to Logic "1" from High Impedance	(Figures 2 and 8)		25	35	ns
B POR	CONTROL FROM OUTPUT DISAE	BLE B INPUT, DS16147/DS36147,	DS16177/E	S36177	<del> </del>	<del></del>
tLZ-	Delay to High Impedance from Logic "0"	(Figures 3 and 5)		15	25	ns
tZL	Delay to Logic "0" from High Impedance	(Figures 3 and 7)		11	17	ns
LATCH	SET-UP AND HOLD TIMES, ALL D	DEVICES		•		
tSET-UF	Set-Up Time of Data Input Before Latch Goes Low		10	0		ns
tHOLD	Hold Time of Data Input After		0			ns

# **Product Description**

DEVICE NUMBER	B PORT TO A PORT FUNCTION	A PORT TO B PORT FUNCTION	A PORT OUTPUTS	B PORT OUTPUTS
DS1647/DS3647	Inverting	Inverting	TRI-STATE	TRI-STATE
DS1677/DS3677	Inverting	Non-Inverting	TRI-STATE	TRI-STATE
DS16147/DS36147	Inverting	Inverting	TRI-STATE	Open-Collector
DS16177/DS36177	Inverting	Non-Inverting	TRI-STATE	Open-Collector

# **Truth Table**

INPUT E	NABLES	LATCH	ОИТРИТ	DISABLES	- Landian	A PORTS	B PORTS B1B4	B PORTS B1-B4	COMMENTS
Α	В	LATCH	А	В	EXPANSION	ALL DEVICES	DS1647, DS16147 DS3647, DS36147	DS1677, DS16177 DS3677, DS36177	COMMENTS
1	0	1	0	0	0	Hi-Z	Ā	Α,	Data In on A, output to B
0	1	1	0	0	0	B	Hi-Z	Hi-Z	Data In on B, output to A
1	0	0	0	0	0	Hi-Z	Ā	Α	Data stored which is present when latch goes low
0	1	0	0	0	0	Ē	Hi-Z	Hi-Z	Data stored which is present when latch goes low
1	0	×	0	1	0	Hi-Z	Hi-Z	Hi-Z	Both A and B in Hi-Z state, Data In on A, may be latched
0	1	×	1	0	0	Hi-Ż	Hi-Z	Hi-Z	Both A and B in Hi-Z state, Data In on B, may be latched
х	×	×	×	×	1	Hi-Z	Hi-Z	Hi-Z	Both A and B in Hi-Z state

# **AC Test Circuits**

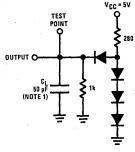


FIGURE 1. A Port Load, All Circuits

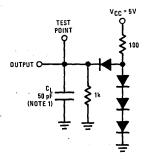


FIGURE 2. B Port Load, DS3647, DS3677

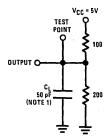
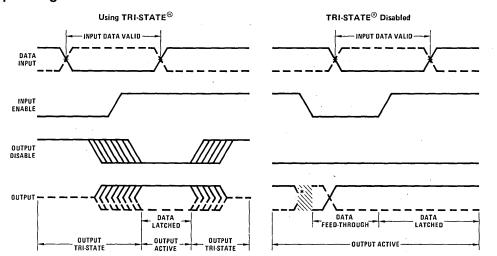


FIGURE 3. B Port Load, DS36147, DS36177

Note 1: CL includes probe and jig capacitance.

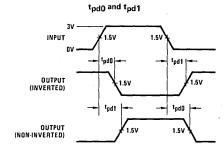
#### **Operating Waveforms**



<sup>\*</sup>When the Input Enable makes a negative transition, the output will be indeterminate for a short duration. The negative transition of the Input Enable normally occurs during a don't-care timing state at the output.

# **Switching Time Waveforms**

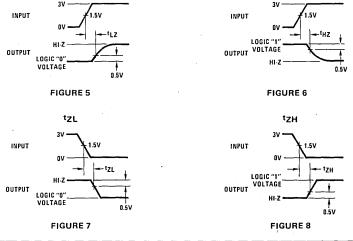
tLZ



Input Characteristics: f = 1 MHz,  $t_R$  =  $t_F \le 5$  ns (10% to 90% points), duty cycle = 50%,  $Z_{OUT}$  = 50  $\Omega$ 

FIGURE 4

tHZ



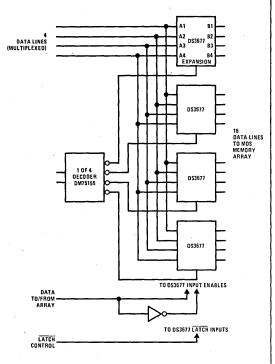
# **Schematic Diagram**

# INPUT O UTPUT INTERNAL LOGIC CIRCUITRY O GND

Note. Data pins A1—A4 and B1—B4 consist of an input and an output tied together.

# **Typical Application**

The diagram below shows how the DS3677 can be used as a register capable of multiplexing data lines.





# DS1648/DS3648, DS1678/DS3678 TRI-STATE® TTL to MOS Multiplexers/Drivers

#### **General Description**

The DS1648/DS3648 and DS1678/DS3678 are quad 2-input multiplexers with TRI-STATE outputs designed to drive the large capacitive loads (up to 500 pF) associated with MOS memory systems. A PNP input structure is employed to minimize input currents so that driver loading in large memory systems is reduced. The circuit employs Schottky-clamped transistors for high speed and TRI-STATE outputs for bus operation.

The DS1648/DS3648 has a 15  $\Omega$  resistor in series with the outputs to dampen transients caused by the fast-switching output. The DS1678/DS3678 has a direct,

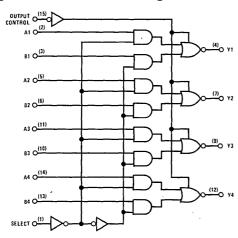
low impedance output for use with or without an external resistor.

**Memory Support** 

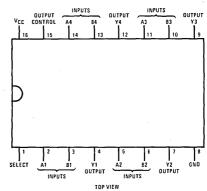
#### **Features**

- TRI-STATE outputs interface directly with system bus
- Schottky-clamped for better ac performance
- PNP inputs to minimize input loading
- TTL compatible
- High-speed capacitive load drivers
- Built-in damping resistor (DS1648/DS3648 only)

#### **Logic and Connection Diagrams**

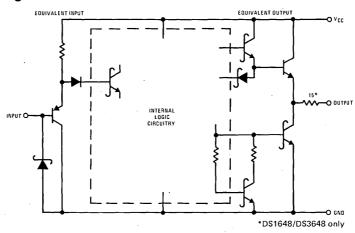


# Dual-In-Line Package



Order Number DS1648J, DS3648J, DS1678J, DS3678J, DS3648N or DS3678N See NS Package J16A or N16A

#### **Schematic Diagram**



Absolute Maximum Ratio	ngs (Note 1)	Operating Condi	tions		
			MIN	MAX	UNITS
Supply Voltage Logical "1" Input Voltage	7V 7V	Supply Voltage (VCC)	4.5	5.5	V
Logical "0" Input Voltage Storage Temperature Range Maximum Power Dissipation* at 25°C	-1.5V -65° C to +150° C	Temperature (TA) DS1648, DS1678 DS3648, DS3678	-55 0	+125 +70	°C °C
Cavity Package Molded Package Lead Temperature (Soldering, 10 seconds)	1433 mW 1362 mW 300° C				
*Derate cavity package 9.6 mW/° C above 25° package 10.9 mW/° C above 25° C.	C; derate molded				

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER		CONDITIONS		MIN	TYP	MAX	UNITS
VIN(1)	Logical "1" Input Voltage				2.0			V
VIN(0)	Logical "0" Input Voltage						0.8	V
<sup>1</sup> IN(1)	Logical "1" Input Current	V <sub>CC</sub> = 5.5V,	V <sub>IN</sub> = 5.5V			0.1	40	μΑ
<sup>1</sup> IN(0)	Logical "0" Input Current	V <sub>CC</sub> = 5.5V,	V <sub>IN</sub> = 0.5V			-50	-250	μА
VCLAMP	Input Clamp Voltage	V <sub>CC</sub> = 4.5V,	I <sub>IN</sub> = -18 mA			-0.75	-1.2	· V
VoH	Logical "1" Output Voltage			DS1648/DS1678	2.7	3.6		V
	(No Load)	V <sub>CC</sub> = 4.5V,	$I_{OH} = -10 \mu A$	DS3648/DS3678	2.8	3.6		V
VOL	Logical "0" Output Voltage		1	DS1648/DS1678		0.25	0.4	V
	(No Load)	VCC = 4.5V,	I <sub>OL</sub> = 10 μA	DS3648/DS3678		0.25	0.35	V
Voн	Logical "1" Output Voltage			DS1648	2.4	3.5		V
	(With Load)	\/ 4 E\/	IOH = -1.0 mA	DS1678	2.5	3.5		V
		vCC - 4.5v,	10H = -1.0 mA	DS3648	2.6	3.5		٧
				DS3678	2.7	3.5		V
VOL	Logical "0" Output Voltage			DS1648		0.6	1.1	V
	(With Load)		I <sub>OL</sub> = 20 mA	DS1678		0.4	0.5	. V
		VCC - 4.5V,	10L - 20 IIIA	DS3648		0.6	1.0	V
				DS3678		0.4	0.5	V
I <sub>1D</sub>	Logical "1" Drive Current	V <sub>CC</sub> = 4.5V,	V <sub>OUT</sub> = 0V, (Note	4)		-250		mA
IOD	Logical "0" Drive Current	V <sub>CC</sub> = 4.5V,	V <sub>OUT</sub> = 4.5V, (Not	e 4)		150		mA
lHi-Z	TRI-STATE Output Current	V <sub>OUT</sub> = 0.4	V to 2.4V, Output C	ontrol = 2.0V	-40		40	μΑ
lcc	Power Supply Current	V <sub>CC</sub> = 5.5V	Output Control = 3 All Other Inputs at			42	60	mA
		`	All Inputs at 0V			20	32	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS1648 and DS1678 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS3648 and DS3678. All typical values are for  $T_{A} = 25^{\circ}$ C and  $V_{CC} = 5V$ .

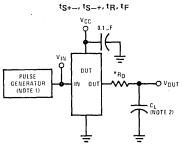
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

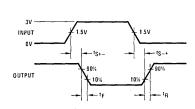
Note 4: When measuring output drive current and switching response for the DS1678 and DS3678 a 15  $\Omega$  resistor should be placed in series with each output. This resistor is internal to the DS1648/DS3648 and need not be added.

# Switching Characteristics (V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C) (Note 4)

	PARAMETER	С	ONDITIONS	MIN	TYP	MAX	UNITS
15+-	Stora je Deray Plagative Euge	(Figure 1)	CL = 50 pF CL = 500 pF		5 9	7 12	ns ns
ts_+	Storage Delay Positive Edge	(Figure 1)	C <sub>L</sub> = 50 pF		6 9	8	ns ns
tF	Falt Time	(Figure 1)	CL = 50 pF		5 22	8 35	ns
tR	Rise Time	(Figure 1)	CL = 500 pF		6 22	9 35	ns
<sup>t</sup> ZL	Delay from Output Control Input to Logical "0" Level (from High Impedance State)		, R <sub>L</sub> = 2 kΩ to V <sub>CC</sub> ,		10	15	ns
†ZH	Delay from Output Control Input to Logical "1" Level (from High Impedance State)	C <sub>L</sub> = 50 pF (Figure 2)	, R <sub>L</sub> = $2 k\Omega$ to Gnd,		8	15	ns
tLZ	Delay from Output Control Input to High Impedance State (from Logical "0" Level)	C <sub>L</sub> = 50 pF (Figure 3)	, R <sub>L</sub> = $400 \Omega$ to V <sub>CC</sub> ,		15	25	ns
tHZ	Delay from Output Control Input to High Impedance State (from Logical "1" Level)	CL = 50 pF (Figure 3)	, R <sub>L</sub> = $400 \Omega$ to Gnd,		10	25	ns
ts+	Propagation Delay to Logical "0" Transition When Select Selects A	CL = 50 pF	, (Figure 1)		12	15	ns
ts-+	Propagation Delay to Logical "1" Transition When Select Selects A	C <sub>L</sub> = 50 pF	, (Figure 1)		14	17	ns
ts+-	Propagation Delay to Logical "0" Transition When Select Selects B	CL = 50 pF	, (Figure 1)		16	20	ns
ts-+	Propagation Delay to Logical "1" Transition When Select Selects B	CL - 50 pF	, (Figure 1)		14	20	ns

# AC Test Circuits and Switching Time Waveforms

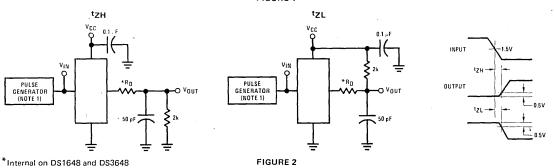




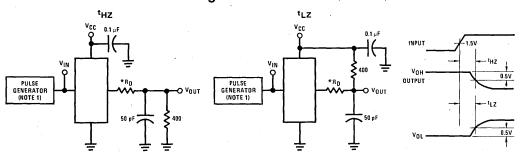
Note 1: The pulse generator has the following characteristics:  $Z_{OUT}$  = 50  $\Omega$  and PRR  $\leq$  1 MHz. Rise and fall times between 10% and 90% points  $\leq$  5 ns.

Note 2: C<sub>L</sub> includes probe and jig capacitance.

FIGURE 1



# AC Test Circuits and Switching Time Waveforms (Continued)



<sup>\*</sup>Internal on DS1648 and DS3648

FIGURE 3

#### **Truth Table**

OUTPUT	INPL	JTS		
CONTROL	SELECT	X X X H L L X L H X H X L	OUTPUTS	
Н	X	X	Х	Hi-Z
L	L	L	Х	н
· L	, L	Н	Х	L
L	. н	×	L	Н
L .	н	X	Н	L

H = High level

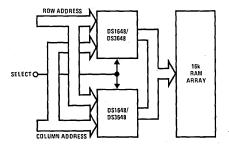
L = Low level

X = Don't care

Hi-Z = TRI-STATE mode

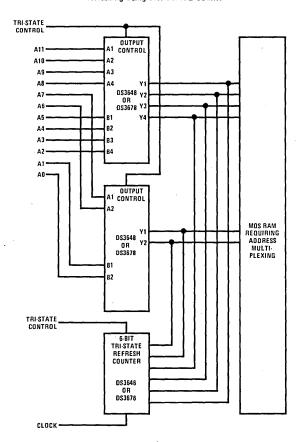
# Typical Applications

#### Addressing 16k RAM

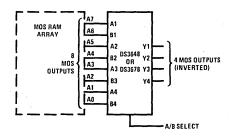


# Typical Applications (Continued)

#### Refreshing Using TRI-STATE Counter



#### 2:1 Multiplexing of RAM Outputs



# National Semiconductor

# **Memory Support**

# DS1649/DS3649, DS1679/DS3679 Hex TRI-STATE® TTL to **MOS Drivers**

#### **General Description**

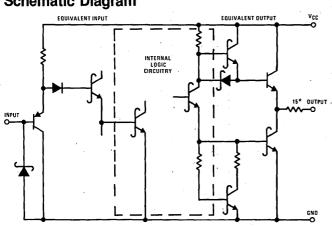
The DS1649/DS3649 and DS1679/DS3679 are Hex TRI-STATE MOS drivers with outputs designed to drive large capacitive loads up to 500 pF associated with MOS memory systems. PNP input transistors are employed to reduce input currents allowing the large fan-out to these drivers needed in memory systems. The circuit has Schottky-clamped transistor logic for minimum propagation delay, and TRI-STATE outputs for bus operation.

The DS1649/DS3649 has a 15  $\Omega$  resistor in series with the outputs to dampen transients caused by the fastswitching output. The DS1679/DS3679 has a direct low impedance output for use with or without an external resistor.

#### **Features**

- High speed capabilities
  - Typ 9 ns driving 50 pF
  - Typ 30 ns driving 500 pF
- TRI-STATE outputs for data bussing
- Built-in 15  $\Omega$  damping resistor (DS1649/DS3649)
- Same pin-out as DM8096 and DM74366

#### Schematic Diagram



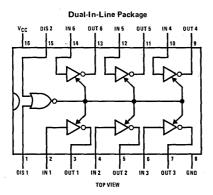
#### Truth Table

	DISABL	E INPUT	INPUT	OUTPUT
ļ	DIS 1	DIS 2	INPUT	001701
	0	0	0	1
	0	0	1 1	0
	0	1	x	Hi-Z
,	1	0	x	Hi-Z
	1	1 -	x	Hi-Z

X = Don't care Hi-Z = TRI-STATE mode

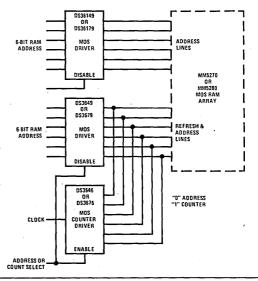
#### \*DS1649/DS3649 only

#### **Connection Diagram**



Order Number DS1649J, DS3649J, DS1679J, DS3679J, DS3649N or DS3679N See NS Package J16A or N16A

#### Typical Application



Absolute Maximum Ratir	1 <b>gs</b> (Note 1)
Supply Voltage	7.0V
Logical "1" Input Voltage	7.0V
Logical "0" Input Voltage	−1.5V
Storage Temperature Range	-65°C to +150°C
Maximum Power Dissipation* at 25°C	
Cavity Package	1371 mW
Molded Package	1280 mW
Lead Temperature (Soldering, 10 seconds)	300°C
Flectrical Characteristics	(Nata 2 and 2)

# **Operating Conditions**

		******	0
Supply Voltage (V <sub>CC</sub> )	4.5	5.5	V
Temperature (TA)			
DS1649, DS1679	-55	+125	°C
DS3649, DS3679	0	+70	°C

\*Derate cavity package 9.1 mW/° C above  $25^{\circ}$  C; derate molded package 10.2 mW/° C above  $25^{\circ}$  C.

	PARAMETER		CONDITIONS	,	MIN	TYP	MAX	UNITS
VIN(1)	Logical "1" Input Voltage				2.0			V
VIN(0)	Logical "0" Input Voltage						0.8	V
<sup>1</sup> IN(1)	Logical "1" Input Current	V <sub>CC</sub> = 5.5V	V <sub>IN</sub> = 5.5V			0.1	40	μΑ
IN(0)	Logical "O" Input Current	V <sub>CC</sub> = 5.5V	V <sub>IN</sub> = 0.5V			-50	-250	μΑ
VCLAMP	Input Clamp Voltage	V <sub>CC</sub> = 4.5V	I <sub>IN</sub> = -18 mA			-0.75	-1.2	٧
VOH	Logical "1" Output Voltage (No Load)	V <sub>CC</sub> = 4.5V	I <sub>OH</sub> = -10 μA	DS1649/DS1679 DS3649/DS3679	2.7	3.6 3.6		V
VOL	Logical "0" Output Voltage	VCC = 4.5V	ΙΟΙ = 10 μΑ	DS1649/DS1679		0.25	0.4	V
	(No Load)			DS3649/DS3679	ļ	0.25	0.35	V
VOH	Logical "1" Output Voltage			DS1649	2.4	3.5		v
	(With Load) VCC = 4.5V	I <sub>OH</sub> = -1.0 mA	DS1679	2.5	3.5		v	
			<b></b>	DS3649	2.6	3.5		V
				DS3679	2.7			
VOL	Logical "0" Output Voltage			DS1649	ļ	0.6	1.1	· V
	(With Load)	V <sub>CC</sub> = 4.5V	IOL = 20 mA	DS1679		0.4	0.5	V
				DS3649	<del></del>	0.6	1.0 0.5	
				DS3679	<del> </del>	0.4	0.5	V
IID	Logical "1" Drive Current	V <sub>CC</sub> = 4.5V	V <sub>OUT</sub> = 0V (Note 4)			-250		mA
IOD	Logical "0" Drive Current	V <sub>CC</sub> = 4.5V	V <sub>OUT</sub> = 4.5V (Note 4)			150		mA
Hi-Z	TRI-STATE Output Current	VOUT = 0.4V DIS1 or DIS2			-40		40	μА
'cc	Power Supply Current	V	One DIS Input = All Other Inputs			42	· 75	mA
		V <sub>CC</sub> = 5.5V	All Inputs = 0V			11	20	mA

# Switching Characteristics ( $V_{CC} = 5V, T_A = 25^{\circ}C$ ) (Note 4)

	PARAMETER	co	NDITIONS	MIN	TYP	MAX	UNITS
ts+_	Storage Delay Negative Edge	(Figure 1)	C <sub>L</sub> = 50 pF C <sub>L</sub> = 500 pF		4.5 7.5	7 .	ns ns
ts_+	Storage Delay Position Edge	(Figure 1)	C <sub>L</sub> = 50 pF C <sub>L</sub> = 500 pF		5 8	8 13	ns ns
tF	Fall Time	(Figure 1)	C <sub>L</sub> = 50 pF C <sub>L</sub> = 500 pF		5 22	8 35	ns ns
t <sub>R</sub>	Rise Time	(Figure 1)	C <sub>L</sub> = 50 pF C <sub>L</sub> = 500 pF		6 21	9 35	ns ns
tZL	Delay from Disable Input to Logical "0" Level (from High Impedance State)	CL = 50 pF to Gnd	$R_L = 2 k\Omega$ to VCC (Figure 2)		10	15	ns
<sup>t</sup> ZH	Delay from Disable Input to Logical "1" Level (from High Impedance State)	CL = 50 pF to Gnd	$R_L = 2 k\Omega$ to Gnd (Figure 2)		8	15	
tLZ	Delay from Disable Input to High Impedance State (from Logical "O" Level)	C <sub>L</sub> = 50 pF to Gnd	R <sub>L</sub> = 400 $\Omega$ to V <sub>CC</sub> (Figure 3)		15	25	
tHZ	Delay from Disable Input to High Impedance State (from Logical "1" Level)	CL = 50 pF to Gnd	R <sub>L</sub> = 400 $\Omega$ to Gnd (Figure 3)		10	25	ns

#### **Notes**

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

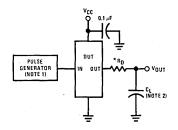
Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS1649 and DS1679 and across the 0°C to  $+70^{\circ}$ C range for the DS3649 and DS3679. All typical values are for  $T_A = 25^{\circ}$ C and  $V_{CC} = 5V$ .

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: When measuring output drive current and switching response for the DS1679 and DS3679 a 15  $\Omega$  resistor should be placed in series with each output. This resistor is internal to the DS1649/DS3649 and need not be added.

#### **AC Test Circuits and Switching Time Waveforms**

ts+-, ts-+, tR, tF



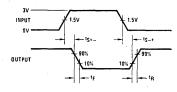
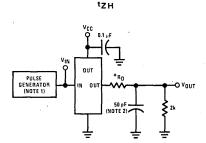
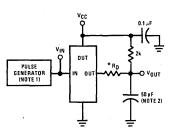


FIGURE 1





tZL

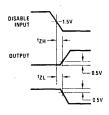
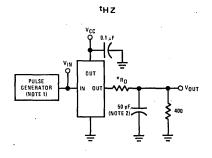
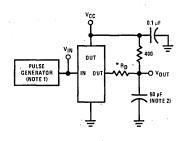


FIGURE 2





tLZ

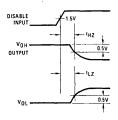


FIGURE 3

Note 1: The pulse generator has the following characteristics:  $Z_{OUT}$  = 50  $\Omega$  and PRR  $\leq$  1 MHz. Rise and fall times between 10% and 90% points  $\leq$  5 ns.

Note 2: CL includes probe and jig capacitance.

<sup>\*</sup>Internal on DS1649 and DS3649



# DS1651/DS3651, DS1653/DS3653 Quad High Speed **MOS Sense Amplifiers**

#### **General Description**

The DS1651/DS3651 and DS1653/DS3653 are TTL compatible high speed circuits intended for sensing in a broad range of MOS memory system applications. Switching speeds have been enhanced over conventional sense amplifiers by application of Schottky technology, and TRI-STATE® strobing is incorporated, offering a high impedance output state for bused organization.

The DS1651/DS3651 has active pull-up outputs, and the DS1653/DS3653 offers open collector outputs providing implied "AND" operations.

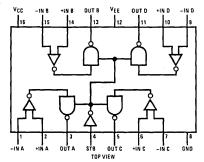
#### **Features**

- High speed
- TTL compatible
- Input sensitivity ±7 mV
- TRI-STATE outputs for high speed buses
  - Standard supply voltages ±5V
- Pin and function compatible with MC3430 and MC3432

**Memory Support** 

#### Connection Diagram

#### **Dual-In-Line Package**



Order Number DS1651J, DS1653J, DS3651J, DS3653J, DS3651N or DS3653N See NS Package J16A or N16A

#### Truth Table

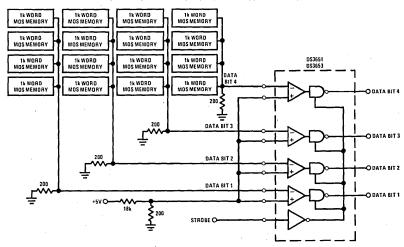
		OUT	PUT
INPUT	STROBE	D\$3651	DS3653
$V_{1D} \ge 7 \text{ mV}$	L.	Н	Open
$T_A = 0^{\circ}C$ to $+70^{\circ}C$	н	Open	Open
$-7 \text{ mV} \leq \text{V}_{\text{ID}} \leq +7 \text{ mV}$	[ L	x	X
$T_A = 0^{\circ}C$ to $+70^{\circ}C$	н	Open	Open
$V_{ID} \leq -7 \text{ mV}$	) L	- L	L,
$T_A = 0^{\circ}C$ to $+70^{\circ}C$	] н	Open	Open

L = Low logic state H = High logic state Open = TRI-STATE

X = Indeterminate state

#### Typical Applications

A Typical MOS Memory Sensing Application for a 4k word by 4-bit memory arrangement employing 1103 type memory devices



Note, Only 4 devices are required for a 4k word by 16-bit memory system.

Absolute Maximum Ratio	ngs	Operating Conditi	ons		
(Note 1)  Power Supply Voltages  VCC VEE	+7 V <sub>DC</sub> -7 V <sub>DC</sub>	Supply Voltage (V <sub>CC</sub> ) DS1651, DS1653 DS3651, DS3653	MIN 4.5 4.75	MAX 5.5 5.25	V <sub>DC</sub>
Differential-Mode Input Signal Voltage Range, V <sub>IDR</sub> Common-Mode Input Voltage Range, V <sub>ICR</sub> Strobe Input Voltage, V <sub>I(S)</sub> Storage Temperature Range Maximum Power Dissipation* at 25°C	±6 VDC ±5 VDC 5.5 VDC -65°C to +150°C	Supply Voltage (VEE)  DS1651, DS1653  DS3651, DS3653  Operating Temperature (T <sub>A</sub> )  DS1651, DS1653  DS3651, DS3653	-4.5 -4.75 -55 0	-5.5 -5.25 +125 +70	VDC VDC °C °C
Cavity Package Molded Package Lead Temperature (Soldering, 10 seconds)	1509 mW 1476 mW 300° C	Output Load Current, (I <sub>OL</sub> ) Differential-Mode Input		16	mA
*Derate cavity package 10.1 mW/°C above 25° package 11.8 mW/°C above 25°C.	C; derate molded	Voltage Range, V <sub>IDR</sub> Common-Mode Input Voltage Range (V <sub>ICR</sub> )	5.0 3.0	+5.0	v <sub>DC</sub>
		Input Voltage Range (Any Input to GND), (VIR)	-5.0	+3.0	V <sub>DC</sub>

#### **Electrical Characteristics**

 $V_{CC} = 5 V_{DC}$ ,  $V_{EE} = -5 V_{DC}$ , Min  $\leq T_A \leq Max$ , unless otherwise noted (Notes 2 and 3)

	PARAMETER		CONDITIO	NS	MIN	TYP	MAX	UNITS
Vis	Input Sensitivity, (Note 5) (Common Mode Voltage Range = $-3V \le V_{IN} \le 3V$ )	Min≤V <sub>CC</sub> ≤ Min≥V <sub>EE</sub> ≥	•				±7.0	mV
VIO	Input Offset Voltage					2		mV
IIB	Input Bias Current	V <sub>CC</sub> = Max, '	VEE = Max				20	μΑ
110	Input Offset Current					0.5		μΑ
VIL(S)	Strobe Input Voltage (Low State)						0.8	V
V <sub>IH(S)</sub>	Strobe Input Voltage (High State)				2			V
IIL(S)	Strobe Current (Low State)	V <sub>CC</sub> = Max, '	VEE = Max, VII	v = 0.4V			-1.6	mA
I <sub>(H(S)</sub>	Strobe Current (High State)		V <sub>1N</sub> = 2.4V	DS3651, DS3653			40	μΑ
		V <sub>CC</sub> = Max,		D33031, D33033			1	mA
		VEE = Max	V <sub>IN</sub> = 2.4V	DS1651, DS1653	<u></u>		100	μΑ
		·	VIN = VCC	<u> </u>			1	mA
VOH	Output Voltage (High State)	VCC = Min, VEE = Min	10 = -400 μΑ	DS1651/DS3651	2.4			, <b>V</b>
VoL	Output Voltage (Low State)	V <sub>CC</sub> = Min,	la = 16 m A	DS3651, DS3653			0.45	V
		VEE = Min	I <sub>O</sub> = 16 mA	DS1651, DS1653			0.50	V
ICEX	Output Leakage Current	V <sub>CC</sub> = Min, V <sub>EE</sub> = Min	V <sub>O</sub> = Max	DS1653/DS3653			250	μΑ
IOS	Output Current Short Circuit	V <sub>CC</sub> = Max, (Note 4)	VEE = Max,	DS1651/DS3651	-18		-70	mA
IOFF	Output Disable Leakage Current			DS3651			40	μΑ
		VCC = Max,	vee = Max	DS1651			100	μΑ
Icc	High Logic Level Supply Current	V <sub>CC</sub> = Max,	VEE = Max			45	60	mA
IEE	High Logic Level Supply Current	V <sub>CC</sub> = Max, '	VFF = Max			-17	-30	mA

#### **Switching Characteristics**

 $V_{CC} = 5 V_{DC}$ ,  $V_{EE} = -5 V_{DC}$ ,  $T_A = 25^{\circ} C$  unless otherwise noted.

	PARAMETER	CONDITIONS	3	MIN	TYP	MAX	UNITS
******	High-to-Low Logic Level Propagation	5 mV + V <sub>IS</sub> , (Figure 3)	DS1651/ DS3651		23	45	ns
<sup>t</sup> PHL(D)	Delay Time (Differential Inputs)	5 111 + V 15, (1 lgule 3)	DS1653/ DS3653		22	50	ns
	Low-to-High Logic Level Propagation	F - V - V - V - V - 21	DS1651/ DS3651		22	55	ns
₹PLH(D)	tPLH(D) Delay Time (Differential Inputs)	5 mV + V <sub>IS</sub> , ( <i>Figure 3</i> )	DS1653/ DS3653		24	65	ns
tPOH(S)	TRI-STATE to High Logic Level Propagation Delay Time (Strobe)	(Figure 1)	DS1651/ DS3651		16	21	ns
tPHO(S)	High Logic Level to TRI-STATE Propagation Delay Time (Strobe)	(Figure 1)	DS1651/ DS3651		7	18	ns
tPOL(S)	TRI-STATE to Low Logic Level Propagation Delay Time (Strobe)	(Figure 1)	DS1651/ DS3651		19	27	ns
tPLO(S)	Low Logic Level to TRI-STATE Propagation Delay Time (Strobe)	(Figure 1)	DS1651/ DS3651		14	29	ns
tPHL(S)	High-to-Low Logic Level Propagation Delay Time (Strobe)	(Figure 2)	DS1653/ DS3653		16	25	ns
<sup>†</sup> PLH(S)	Low-to-High Logic Level Propagation Delay Time (Strobe)	(Figure 2)	DS1653/ DS3653		13	25	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

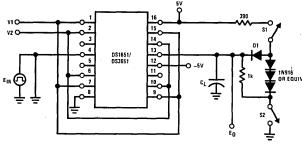
Note 2: Unless otherwise specified min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS3651, DS3653 and across the  $-55^{\circ}$ C to  $+125^{\circ}$ C range for the DS1651, DS1653. All typical values are for TA =  $25^{\circ}$ C, V<sub>CC</sub> = 5V and V<sub>EE</sub> = -5V.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: A parameter which is of primary concern when designing with sense amplifiers is, what is the minimum differential input voltage required at the sense amplifier input terminals to guarantee a given output logic state. This parameter is commonly referred to as threshold voltage. It is well known that design considerations of threshold voltage are plagued by input offset currents, bias currents, network source resistances, and voltage gain. As a design convenience, the DS1651, DS1653 and DS3651, DS3653 are specified to a parameter called input sensitivity ( $V_{LS}$ ). This parameter takes into consideration input offset currents and bias currents, and guarantees a minimum input differential voltage to cause a given output logic state with respect to a maximum source impedance of 200 $\Omega$  at each input.

#### **AC Test Circuits and Switching Time Waveforms**



Note. Output of channel B shown under test, other channels are tested similarly.

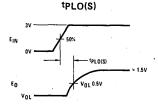
	V1	V2	S1	S2	CL
tPLO(S)	100 mV	GND	Closed	Closed	15 pF
tPOL(S)	100 mV	GND	Closed	Open	50 pF
tPHO(S)	GND	100 mV	Closed	Closed	15 pF
tPOH(S)	GND	100 mV	Open	Closed	50 pF

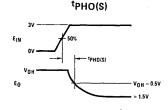
CL includes jig and probe capacitance.

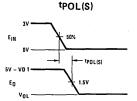
 $E_{\mbox{\footnotesize{IN}}}$  waveform characteristics:  $t_{\mbox{\footnotesize{TLH}}}$  and  $t_{\mbox{\footnotesize{THL}}} \leq 10$  ns measured 10% to 90%

measured 10% PRR = 1 MHz

Duty cycle = 50%



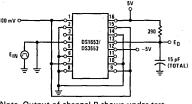




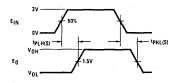


tPOH(S)

FIGURE 1. Strobe Propagation Delay tpLO(S), tpOL(S), tpHL(S) and tpOH(S)

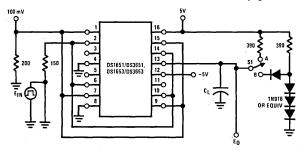


Note. Output of channel B shown under test, other channels are tested similarly.

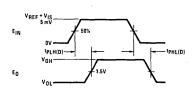


Note. E $_{IN}$  waveform characteristics: t $_{TLH}$  and t $_{THL} \le 10$  ns measured 10% to 90% PRR = 1 MHz, duty cycle = 500 ns

#### FIGURE 2. Strobe Propagation Delay tpLH(S) and tpHL(S)

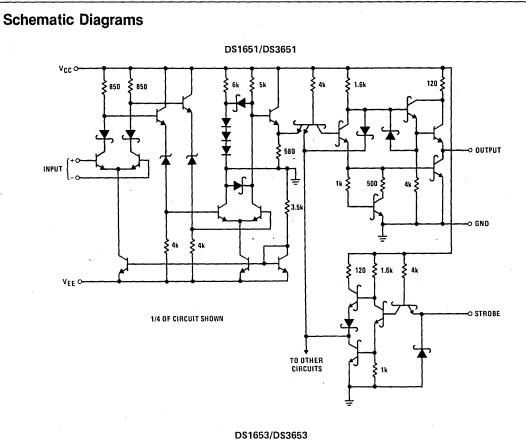


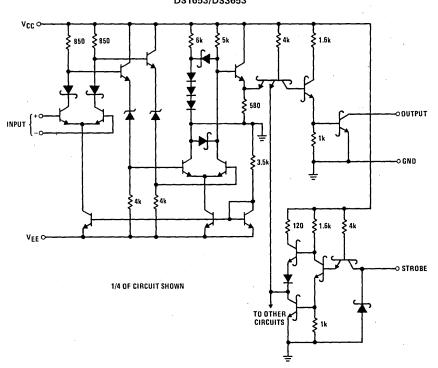
Note. Output of channel B shown under test, other channels are tested similarly. S1 at "A" for DS1653/DS3653, C $_L$  = 15 pF total for DS1653/DS3653 S1 at "B" for DS1651/DS3651, C $_L$  = 50 pF total for DS1651/DS3651



 $E_{IN}$  waveform characteristics:  $t_{TLH}$  and  $t_{THL} \le 10$  ns measured 10% to 90% PRR = 1 MHz, duty cycle = 500 ns

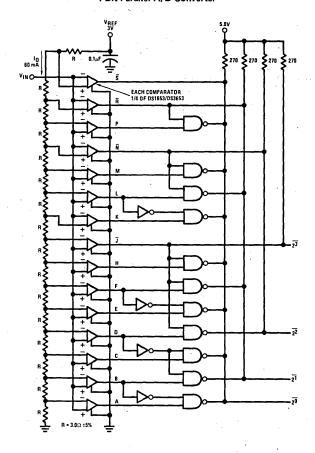
FIGURE 3. Differential Input Propagation Delay tpLH(D) and tpHL(D)





# Typical Applications (Continued)

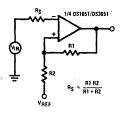
#### 4-Bit Parallel A/D Converter



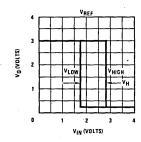
# 

Conversion time  $\cong$  50 ns

#### Level Detector with Hysteresis



# Transfer Characteristics and Equations for Level Detector with Hysteresis



$$V_{HIGH} = V_{REF} + \frac{R2 [V_{O(MAX)} - V_{REF}]}{R1 + R2}$$
 $V_{LOW} = V_{REF} + \frac{R2 [V_{O(MIN)} - V_{REF}]}{R1 + R2}$ 

Hysteresis Loop (VH)

$$V_{H} = V_{HIGH} - V_{LOW} = \frac{R2}{R1 + R2} [V_{O(MAX)} - V_{O(MIN)}]$$

# **Memory Support**

# DS1671/DS3671 Bootstrapped Two Phase MOS Clock Driver

#### **General Description**

The DS1671/DS3671 is a high speed dual MOS clock driver and interface circuit. Unique circuit design provides both very high speed operation and the ability to drive large capacitive loads. The device accepts standard TTL outputs and converts them to MOS logic levels. It may be driven from standard 54/74 and 54S/ 74S series gates and flip-flops or from drivers such as the DS8830 or DM7440. The circuit can be used in both P-channel and N-channel MOS memory system drive applications.

The DS1671/DS3671 is intended to fulfill a wide variety of MOS interface requirements. As a MOS clock driver for long silicon gate shift registers, a single device can drive over 10k bits at 5 MHz. Six devices provide input address and precharge drive for an 8k by 16-bit 1103 RAM memory system.

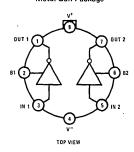
Each driver uses output bootstrapping to provide a higher voltage to the output stage, thus eliminating the need for an additional  $V_{\text{DD}}$  supply. The bootstrapping function is accomplished by connecting a small value capacitor (typically 200 pF) from each output to each drivers bootstrap node.

#### **Features**

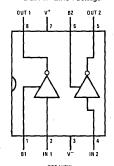
- Fast rise and fall times-20 ns with 1000 pF load
- High output swing-20V
- High output current drive-±1.5A
- TTL compatible inputs
- High rep rate-5 to 10 MHz depending on power dissipation
- Low power consumption in MOS "0" state-2 mW
- Swings to 0.4V of GND for RAM address drive

#### **Connection Diagrams**

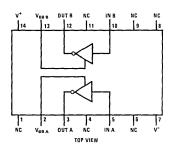
Metal Can Package



Dual-In-Line Package



Dual-In-Line Package

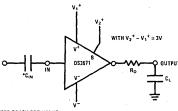


Order Number DS1671H or DS3671H See NS Package H08C

Order Number DS1671J-8, DS3671J-8 or DS3671N See NS Package J08A or N08A

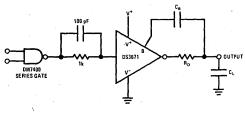
Order Number DS1671J or DS3671J See NS Package J14A

#### Typical Applications



SEE GRAPH FOR VALUE

DS3671 Operating with Extra Supply to Inhance Output Voltage Level



Bootstrap Clock Driver Driven from a TTL Gate

#### Absolute Maximum Ratings (Note 1) V<sup>+</sup> – V<sup>-</sup> Differential VR - V Differential 40V VB - V+ Differential 20V Input Voltage (VIN - V-) 5.5V Input Current 100 mA Peak Output Current 1.5A Storage Temperature Range -65°C to +150°C Lead Temperature (Soldering, 10 seconds) 300° C Maximum Power Dissipation\* at 25°C Cavity Package (8-Pin) 1150 mW Cavity Package (14-Pin) 1380 mW Molded Package 1040 mW

#### **Operating Conditions**

	MIN	MAX	UNITS
Supply Voltage			
V <sup>+</sup> − V <sup>−</sup> Differential		20	V
VB - V Differential		40	V
$V_B^ V^+$ Differential		20	V
Operating Temperature Range			
DS3671	0	+70	°C
DS1671	-55	+125	°C ,

\*Derate 8-pin cavity package 7.7 mW/°C above 25°C; derate 14-pin cavity package 9.3 mW/°C above 25°C; derate molded package 8.4 mW/°C above 25°C; derate metal can (TO-5) package 4.4 mW/°C above 25°C.

#### Electrical Characteristics (Notes 2 and 3)

Metal Can (TO-5) Package

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
VIH	Logical "1" Input Voltage	V = 0V		2.0	1.5		V
l <sub>IH</sub>	Logical "1" Input Current	V <sub>IN</sub> - V = 2.4V			10	15	mA
VIL	Logical "0" Input Voltage	V <sup>-</sup> = 0V			0.6	0.4	V
I <sub>IL</sub>	Logical "0" Input Current	V <sub>IN</sub> - V" = 0V			-3	-10	μΑ
VoH	Logical "1" Output Voltage	$V_B \ge V^+ + 1.0V, V_{IN} - V^- \equiv 0.4V,$	DS3671	V <sup>+</sup> -1.0	V <sup>+</sup> −0.75		V
		I <sub>O</sub> = 0 mA	DS1671	V <sup>+</sup> -1.2	V <sup>+</sup> −0.75		V
Vol .	Logical "0" Output Voltage	V <sub>IN</sub> - V = 2.4V, I <sub>O</sub> = 0 mA			V~+0.6	V <sup></sup> +1.0	V
R <sub>8</sub>	Bootstrap Control Resistor			1.1	2.0	3.3	kΩ
I <sub>CC(ON)</sub>	Supply Current One Side "ON"	$V^{+} - V^{-} = 20V, V_{1N} - V^{-} = 2.4V,$ $V_{B} = V^{+}$			30	40	mA
I <sub>CC(OFF)</sub>	Supply Current "OFF"	$V^{+} - V^{-} = 20V, V_{1N} - V^{-} = 0V$	DS3671		10	100	μА
			DS1671		50	500	μΑ

660 mW

#### Switching Characteristics $T_A = 25^{\circ}\text{C}, \text{ V}^{+} = 20\text{V}, \text{ V}^{-} = 0\text{V}$

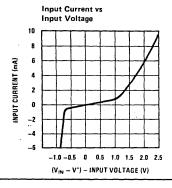
	PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>pd0</sub>	Propagation Delay to a Logical "0"	$R_D = 10\Omega$	, C <sub>L</sub> ≈ 1000 pF		7.5	15	ns
t <sub>pd1</sub>	Propagation Delay to a Logical "1"	$R_D = 10\Omega$	, C <sub>L</sub> = 1000 pF		12	15	ns
t <sub>r</sub>	Rise Time	R <sub>D</sub> = 10Ω	C <sub>L</sub> = 500 pF C <sub>L</sub> = 1000 pF		25	35	ns
			C <sub>L</sub> = 1000 pF		31	40	ns
t <sub>f</sub>	Fall Time	B = 100	C <sub>L</sub> = 500 pF		30	40	ns
		$R_D = 10\Omega$	C <sub>L</sub> = 1000 pF		38	50	ns

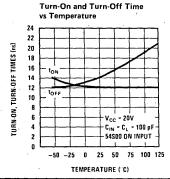
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

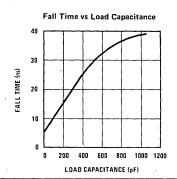
Note 2: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DS1671 and across the 0°C to +70°C range for the DS3671. All typicals at 25°C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

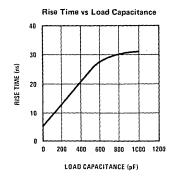
# **Typical Performance Characteristics**

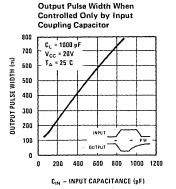




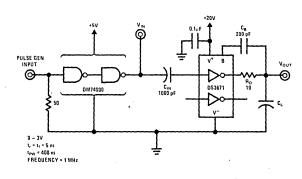


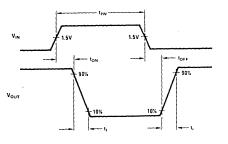
#### Typical Performance Characteristics (Continued)



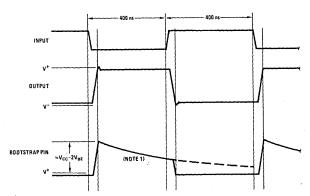


#### **AC Test Circuit and Switching Time Waveforms**





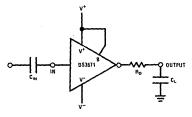
# **Node Voltage Waveforms**



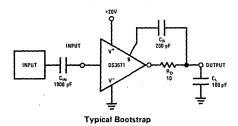
Note 1: The fall time has an exponential decay with the following time constant:  $t_B = C_B R_B$ . The range of values for  $R_B$  (resistor tolerance, and temperature coefficient included) can be found in the table of electrical characteristics.

Note 2: The high current transinct is ship as 1.5.4) through the resistance of the external interconnecting V<sup>\*</sup> lead during the output transition from the high state to the low state can appear as negative feedback to the injust. If the external interconnecting lead from the driving circuit to V<sup>\*</sup> is electrically long, or has significant DC resistance, it can subtract from the synthispin response.

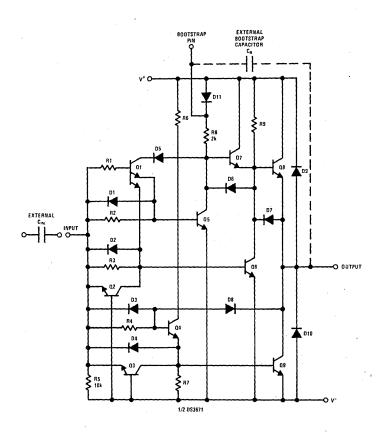
#### Typical Applications (Continued)



DS3671 Connected as DS0026 with Equivalent Characteristics



# Schematic Diagram (One Driver)



#### **DS3685 Hex TRI-STATE® Latch**

#### **General Description**

The DS3685 is a hex latch. PNP input transistors are used to reduce input currents, allowing large fan-out to these drivers. The circuit has Schottky-clamped transistor logic for minimum propagation delay, and TRI-STATE outputs which allow bus operation.

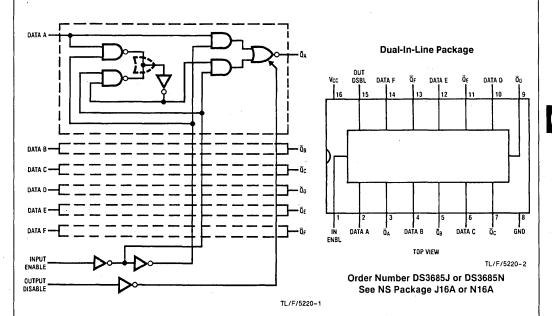
The circuit employs a fall-through latch which captures the data in parallel with the output, thereby eliminating the delay normally encountered in other latch circuits.

TRI-STATE® is a registered trademark of National Semiconductor Corp.

#### **Features**

- TTL/LS compatible inputs
- PNP inputs minimize loading
- **■** TRI-STATE outputs
- Fall-through latch design
- Minimum skew

#### **Logic and Connection Diagrams**



#### **Truth Table**

input Enable	Output Disable	Data	Output	Operation
1	0	1	0	Data Feed-Through
1	0	0	1	Data Feed-Through
	0	×	- α	Latched to Data Present when Enable Went Low
X	1	X	Hi-Z	High Impedance Output

X = don't care

Hi-Z = TRI-STATE mode

#### **Absolute Maximum Ratings (Note 1)**

 Supply Voltage, V<sub>CC</sub>
 7V

 Logical '1" Input Voltage
 7V

 Logical "0" Input Voltage
 -1.5V

 Storage Temperature Range
 -65°C to 150°C

Lead Temperature (Soldering, 10 seconds)

Maximum Power Dissipation\* at 25°C

Cavity Package Molded Package 1433 mW 1362 mW

300°C

\*Derate cavity package 9.6 mW/°C above 25°C; derate molded package 10.9 mW/°C above 25°C.

#### **Operating Conditions**

	Min	Max	Units
Supply Voltage (V <sub>CC</sub> )	4.5	5.5	٧
Temperature (T <sub>A</sub> )	0	+70	°C

#### Electrical Characteristics (Notes 2 and 3)

	Parameter	Cond	tions	Min	Тур	Max	Units
V <sub>IN</sub> (1)	Logical "1" Input Voltage			2.0			٧
V <sub>IN</sub> (0)	Logical "0" Input Voltage					0.8	V
			Enable Inputs		0.1	40	μΑ
I <sub>IN</sub> (1)	Logical "1" Input Current	V <sub>IN</sub> = 5.5V, V <sub>CC</sub> = Max	Data Inputs		0.2	80	μА
			Enable Inputs		- 50	-300	μА
I <sub>IN</sub> (0)	Logical "0" Input Current	$V_{IN} = 0.5V, V_{CC} = Max$	Data Inputs		-100	-500	μА
VCLAMP	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18 mA			-0.75	-1.2	V
los	Output Short-Circuit Current	V <sub>CC</sub> = Max, V <sub>OUT</sub> = 0V, (Note 4	)	-40		-100	mA
.,			I <sub>OH</sub> = -1 mA	2.5	3.5		٧
VOH	Logical "1" Output Voltage	V <sub>CC</sub> = Min	$I_{OH} = -10 \mu A$	2.8	3.8		٧
			I <sub>OL</sub> = 20 mA		0.4	0.5	٧
V <sub>OL</sub>	Logical "0" Output Voltage	V <sub>CC</sub> = Min	I <sub>OL</sub> = 10 μA		0.25	0.35	V
I <sub>HZ</sub>	TRI-STATE Output Current	V <sub>OUT</sub> = 0.4V to 2.4V, Output Dis	able = 2V	-40		40	μА
lcc	Power Supply Current	V <sub>CC</sub> = Max, All Inputs = 3V = 0	V, Enable = 3V			90	mA

# Switching Characteristics $V_{CC} = 5V$ , $T_A = 25$ °C, unless otherwise noted.

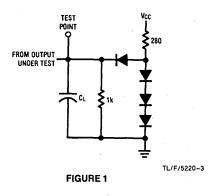
	Parameter	Conditions	Min	Тур	Max	Units
tpHL	Propagation Delay Time Low-to-High Level Output	$C_L = 15 \text{ pF}, R_L = 280\Omega$ , (Figures 1 and 2)		5.5	7.0	ns
tрцн	Propagation Delay Time, High-to-Low Level Output	$C_L = 15 \text{ pF}, R_L = 280\Omega, (Figures 1 \text{ and 2})$		4.5	6.0	ns
t <sub>PHL</sub>	Propagation Delay Time, Low-to-High Level Output	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 280Ω, (Figures 1 and 2)		8		ns
<sup>t</sup> PLH	Propagation Delay Time, High-to-Low Level Output	C <sub>L</sub> = 50 pF, R <sub>L</sub> = 280Ω, (Figures 1 and 2)		6		ns
tSET-UP	Set-Up Time on Data Input Before Input Enable Goes Low		10	0		ns
tHOLD	Hold Time on Data Input After Input Enable Goes Low		0			ns
<sup>t</sup> ZL	Delay from Disable Input to Logical "0" Level (from High Impedance State)	C <sub>L</sub> = 15 pF, (Figures 1 and 3)		8.2	15	ns
t <sub>ZH</sub>	Delay from Disable Input to Logical "1" Level (from High Impedance State)	C <sub>L</sub> = 15 pF, (Figures 1 and 3)		17	24	ns
t <sub>LZ</sub>	Delay from Disable Input to High Impedance State (from Logical "0" Level)	C <sub>L</sub> = 15 pF, (Figures 1 and 4)		7.7	14	ns
t <sub>HZ</sub>	Delay from Disable Input to High Impedance State (from Logical "1" Level)	C <sub>L</sub> = 15 pF, (Figures 1 and 4)		5.5	12	ns

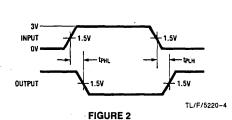
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

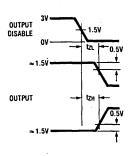
Note 2: Unless otherwise specified min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS3685. All typical values are for  $T_A = 25^{\circ}$ C and  $V_{CC} = 5V$ . Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

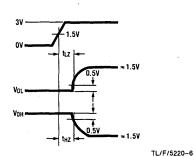
Note 4: Only one output should be shorted at one time.

#### **AC Test Circuit and Switching Time Waveforms**









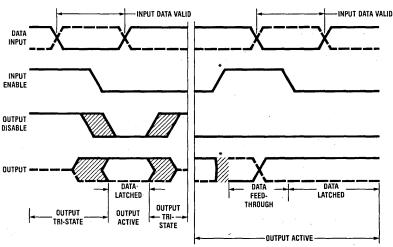
Input characteristics: PRR  $\leq$  1 MHz,  $Z_{OUT}=50\Omega,\,t_{r}\leq$  2.5 ns,  $t_{f}\leq$  2.5 ns. FIGURE 3

TL/F/5220-5

FIGURE 4

TL/F/5220-7

# **Operating Waveforms**



\*When the Input Enable makes a positive transition the output will be indeterminate for a short duration.

The positive transition of the Input Enable normally occurs during a don't-care timing state at the output.

National Semiconductor **General Description** 

# **Memory Support**

# DS16149/DS36149, DS16179/DS36179 Hex MOS Drivers

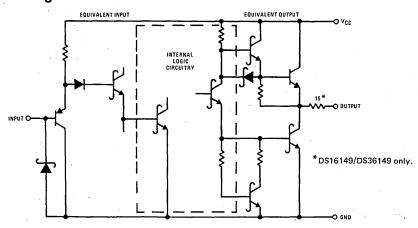
The DS16149/DS36149 and DS16179/DS36179 are Hex MOS drivers with outputs designed to drive large capacitive loads up to 500 pF associated with MOS memory systems. PNP input transistors are employed to reduce input currents allowing the large fan-out to these drivers needed in memory systems. The circuit has Schottky-clamped transistor logic for minimum propagation delay, and a disable control that places the outputs in the logic "1" state (see truth table). This is especially useful in MOS RAM applications where a set of address lines has to be in the logic "1" state during refresh.

The DS16149/DS36149 has a 15  $\Omega$  resistor in series with the outputs to dampen transients caused by the fastswitching output. The DS16179/DS36179 has a direct low impedance output for use with or without an external resistor.

#### **Features**

- High speed capabilities
  - Typ 9 ns driving 50 pF Typ 29 ns driving 500 pF
- Built-in 15 Ω damping resistor (DS16149/DS36149)
- Same pin-out as DM8096 and DM74366

#### Schematic Diagram



# **Connection Diagram**

# Dual-In-Line Package

Order Number DS16149J, DS36149J, DS16179J, DS36179J, DS36149N or DS36179N See NS Package J16A or N16A

#### **Truth Table**

DISABL	DISABLE INPUT		OUTPUT		
DIS 1	DIS 2	INPUT	001701		
0	0	0	1,		
0	. 0	1	0		
0	1	х	1		
1	0.	х	1		
1	1	X	1		

X = Don't care

#### Absolute Maximum Ratings (Note 1) **Operating Conditions** MAX UNITS Supply Voltage 7.0V Supply Voltage (V<sub>CC</sub>) 4.5 5.5 ٧ Logical "1" Input Voltage 7.0V Temperature (TA) -1.5V Logical "0" Input Voltage DS16149, DS16179 --55 +125 °C -65°C to +150°C Storage Temperature Range °c DS36149, DS36179 0 +70 Maximum Power Dissipation\* at 25°C 1371 mW Cavity Package Molded Package 1280 mW 300°C Lead Temperature (Soldering, 10 seconds)

#### DC Electrical Characteristics (Notes 2 and 3)

	PARAMETER		CONDITION	S	MIN	TYP	MAX	UNITS
VIN(1)	Logical "1" Input Voltage				2.0			V
VIN(0)	Logical "0" Input Voltage						0.8	٧
I <sub>IN(1)</sub>	Logical "1" Input Current	V <sub>CC</sub> = 5.5V	V <sub>IN</sub> = 5.5V			0.1	40	μА
<sup>1</sup> IN(0)	Logical "0" Input Current	V <sub>CC</sub> = 5.5V	V <sub>IN</sub> = 0.5V			-50	-250	μΑ
VCLAMP	Input Clamp Voltage	V <sub>CC</sub> = 4.5V	IIN = -18 mA			-0.75	-1.2	٧
VOH	Logical "1" Output Voltage	Vac = 4 5V	$V_{CC} = 4.5V$ $I_{OH} = -10 \mu A$ DS16		3.4	4.3		· V
	(No Load)	VCC - 4.5V			3.5	4.3		V
VOL	Logical "0" Output Voltage	V45V	DS			0.25	0.4	V
	(No Load)	V <sub>CC</sub> = 4.5V I <sub>OL</sub> = 10 μA		DS36149/DS36179		0.25	0.35	V
Voн	Logical "1" Output Voltage	utput Voltage	DS16149 DS16179 DS36149	DS16149	2.4	3.5		٧
	(With Load)	V00 = 4.5V		DS16179	2.5	3.5		V
		VCC - 4.5V		DS36149	2.6	3.5		V
				DS36179	2.7	3.5		V
VOL	Logical "0" Output Voltage			DS16149		0.6	1.1	V
	(With Load)	\/oo = 4 E\/	IOL = 20 mA	DS16179		0.4	0.5	V
		VCC - 4.5V	10E - 20 IIIA	DS36149	1 1	0.6	1.0	V
				DS36179		0.4	0.5	. V
liD ,	Logical "1" Drive Current	V <sub>CC</sub> = 4.5V	V <sub>OUT</sub> = 0V, (N	lote 4)		-250		mA
lop	Logical "0" Drive Current	V <sub>CC</sub> = 4.5V	V <sub>OUT</sub> = 4.5V,	(Note 4)	:	150		mA
Icc	Power Supply Current	Vcc = 5.5V	Disable Inputs = All Other Input			33	60	mA
		vCC = 5.5V	All Inputs = 0V			14	20	mA

# Switching Characteristics (V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C) (Note 4)

	PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
ts+_	Storage Delay Negative Edge	/r: 11	CL = 50 pF		4.5	7	ns
	V W.1	(Figure 1)	C <sub>L</sub> = 500 pF		7.5	12	ns
t <sub>S-+</sub>	Storage Delay Positive Edge	(Figure 1)	C <sub>L</sub> = 50 pF		5	8	ns
		(Figure 1)	C <sub>L</sub> = 500 pF		8	13	ns
tF	Fall Time	/F: 11	CL = 50 pF		5	8	ns
	. (Figur	(Figure 1)	C <sub>L</sub> = 500 pF		22	35	ns
tR	Rise Time	/F: 11	C <sub>L</sub> = 50 pF		6	9	ns
		(Figure 1)	C <sub>L</sub> = 500 pF		26	35	ns
<sup>t</sup> LH	Delay from Disable Input to Logical "1"	$R_L = 2 k\Omega$ to Gnd, $C_L = 50 pF$ , (Figure 2)			15	22	ns
tHL	Delay from Disable Input to Logical "0"	R <sub>L</sub> = 2 kΩ 1	to V <sub>CC</sub> , C <sub>L</sub> = 50 pF, (Figure 3)		11	18	ns

<sup>\*</sup>Derate cavity package 9.1 mW/°C above 25°C; derate molded package 10.2 mW/°C above 25°C.

#### **Notes**

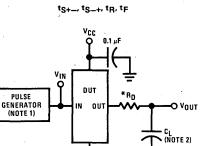
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS16149 and DS16179 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS36149 and DS36179. All typical values are for T<sub>A</sub> =  $25^{\circ}$ C and V<sub>CC</sub> = 5V.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: When measuring output drive current and switching response for the DS16179 and DS36179 a 15  $\Omega$  resistor should be placed in series with each output. This resistor is internal to the DS16149/DS36149 and need not be added.

#### **AC Test Circuits and Switching Time Waveforms**



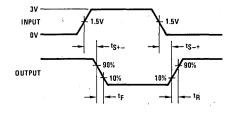
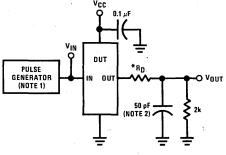


FIGURE 1



<sup>t</sup>LH

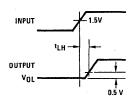
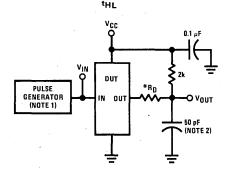


FIGURE 2



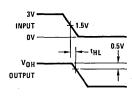


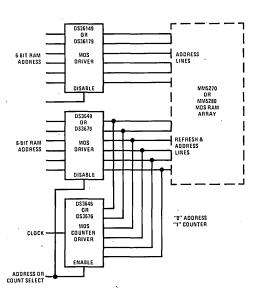
FIGURE 3

Note 1: The pulse generator has the following characteristics:  $Z_{OUT}$  = 50  $\Omega$  and PRR  $\leq$  1 MHz. Rise and fall times between 10% and 90% points  $\leq$  5 ns.

Note 2: C<sub>L</sub> includes probe and jig capacitance.

<sup>\*</sup>Internal on DS16149 and DS36149

# Typical Application





# **Memory Support**

# DS55325/DS75325 Memory Drivers General Description

The DS55325 and DS75325 are monolithic memory drivers which feature high current outputs as well as internal decoding of logic inputs. These circuits are designed for use with magnetic memories.

The circuit contains two 600 mA sink-switch pairs and two 600 mA source-switch pairs. Inputs A and B determine source selection while the source strobe  $(S_1)$  allows the selected source turn on. In the same manner, inputs C and D determine sink selection while the sink strobe  $(S_2)$  allows the selected sink turn on.

Sink-output collectors feature an internal pull-up resistor in parallel with a clamping diode connected to  $V_{CC2}$ . This protects the outputs from voltage surges associated with switching inductive loads.

The source stage features Node R which allows extreme flexibility in source current selection by controlling the amount of base drive to each source transistor. This method of setting the base drive brings the power associated with the resistor outside the package thereby allowing the circuit to

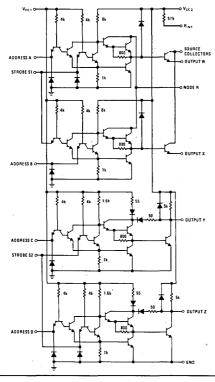
operate at higher source currents for a given junction temperature. If this method of source current setting is not desired, then Nodes R and  $R_{\rm INT}$  can be shorted externally activating an internal resistor connected from  $V_{\rm CC2}$  to Node R. This provides adequate base drive for source currents up to 375 mA with  $V_{\rm CC2}$  = 15V or 600 mA with  $V_{\rm CC2}$  = 24V.

The DS55325 operates over the fully military temperature range of  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ , while the DS5325 operates from  $0^{\circ}\text{C}$  to  $+70^{\circ}\text{C}$ .

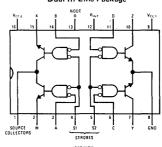
#### **Features**

- 600 mA output capability
- 24V output capability
- Dual sink and dual source outputs
- Fast switching times
- Source base drive externally adjustable
- Input clamping diodes
- TTL compatible

# **Schematic and Connection Diagrams**



#### Dual-In-Line Package



Order Number DS55325J, DS75325J, or DS75325N See NS Package J14A or N14A

#### **Truth Table**

ADI	DRES	S INP	UTS	STROBE	INPUTS		OUT	PUTS	
sou	RCE	s	INK	SOURCE	SINK	sou	RCE	SIN	ıĸ
Α	В	С	D	<b>S</b> 1	\$2	w	x	Y	z
L	Н	×	×	L	н	ON	OFF	OFF	OFF
н	L	х	X	L	н	OFF	ON	OFF	OFF
X	×	L	н	н	L	OFF	OFF	ON	OFF
X	x	н	L	н	L	OFF	OFF	OFF	ON
X	х	х	X	н .	н	OFF	OFF	OFF	OFF
н	н	н	н	×	×	OFF	OFF	OFF	OFF

H = high level, L = low level, X = irrelevant NOTE: Not more than one output is to be on at any one time.

#### Absolute Maximum Ratings (Note 1)

#### **Operating Conditions**

Temperature (TA)

DS55325

DS75325

MIN

-55

0

MAX

+125

+70

UNITS

°C

Subbit Aoitage ACC1 (Note 2)	/ /	
Supply Voltage V <sub>CC2</sub> (Note 5)	25V	
Input Voltage (Any Address or Strobe Input)	5.5V	
Storage Temperature Range	–65°C to +150°C	
Maximum Power Dissipation* at 25°C		
Cavity Package	1509 mW	
Molded Package	1476 mW	
Lead Temperature (Soldering, 10 seconds)	300°C	

\*Derate cavity package 10.1 mW/°C above 25°C; derate molded package 11.8 mW/°C above 25°C.

#### Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITI	ONS		MIN	TYP	MAX	UNITS
V <sub>IH</sub>	High Level Input Voltage	(Figures 1 and 2)		2 .			V	
VIL	Low Level Input Voltage	(Figures 3 and 4)					0.8	V
Vı	Input Clamp Voltage	$V_{CC1} = 4.5V, V_{CC2} = 24V, I_1$ $T_A = 25^{\circ}C, (Figure 5)$	<sub>N</sub> = −12 mA,			-1.3	-1.7	V
loff	Source Collectors Terminal	Full Range DS55325				500	μΑ	
	"OFF" State Current	$V_{CC1} = 4.5V, V_{CC2} = 24V,$		DS75325			200	μΑ
		(Figure 1)	Figure 1) T <sub>A</sub> = 25°C	DS55325		3	150	μΑ
			1 A 20 0	DS75325		3	200	μΑ
V <sub>OH</sub>	High Level Sink Output Voltage	V <sub>CC1</sub> = 4.5V, V <sub>CC2</sub> = 24V, I <sub>C</sub>	<sub>DUT</sub> = 0, (Fig	ure 2)	19	23		V
V <sub>SAT</sub>	Saturation Voltage Source Outputs	$V_{CC1} = 4.5V$ , $V_{CC2} = 15V$ , $R_{L} = 24\Omega$ ,				0.9	V	
	00.00	I <sub>SOURCE</sub> ≈ −600 mA,	T <sub>A</sub> = 25°C	DS55325		0.43	0,7	V
		(Figure 3), (Notes 4 and 6)	$T_A = 25^{\circ}C$	DS75325		0.43	0.75	V
V <sub>SAT</sub>	$R_L = 24\Omega$ ,	Full Range				0.9	V	
		I <sub>SINK</sub> ≈ 600 mA, (Figure 4),		DS55325		0.43	0.7	V
		(Notes 4 and 6)	T <sub>A</sub> = 25°C	DS75325		0.43	0.75	V
I <sub>t</sub>	Input Current at Maximum	V <sub>CC1</sub> = 5.5V, V <sub>CC2</sub> = 24V,	Address Inp	uts			1	mA
	Input Voltage	V <sub>1</sub> = 5.5V, <i>(Figure 5)</i>	Strobe Inpu	ts			2	mA
I <sub>tH</sub>	High Level Input Current	V <sub>CC1</sub> = 5.5V, V <sub>CC2</sub> = 24V,	Address Inp	uts		3	40	μΑ
		V <sub>1</sub> = 2.4V, (Figure 5)	Strobe Inpu	ts		6	80	μА
I <sub>IL</sub>	Low Level Input Current	V <sub>CC1</sub> = 5.5V, V <sub>CC2</sub> = 24V,	Address Inp	uts		-1	-1.6	mA
		V <sub>1</sub> = 0.4V, (Figure 5)	Strobe Inpu	ts		-2	-3.2	mA
I <sub>CC OFF</sub>	Supply Current, All Sources and	V <sub>CC1</sub> = 5.5V, V <sub>CC2</sub> = 24V,	V <sub>CC1</sub>			14	22	mA
	Sinks "OFF"	T <sub>A</sub> = 25°C, (Figure 6)	V <sub>CC2</sub>			7.5	20	mA
I <sub>CC1</sub> .	Supply Current From V <sub>CC1</sub> , Either Sink "ON"	$V_{CC1} = 5.5V, V_{CC2} = 24V, I_{S}$ $T_{A} = 25^{\circ}C, (Figure 7)$	SINK = 50 mA	,	- <del>-</del>	55	70 ·	mA
I <sub>CC2</sub>	Supply Current From V <sub>CC2</sub> , Either Source "ON"	$V_{CC1} = 5.5V, V_{CC2} = 24V, I_{S}$ $T_A = 25^{\circ}C, (Figure 8)$	SOURCE = -50	) mA,		32	50	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DS55325 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS75325. All typical values are at  $T_{A}$  = 25°C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

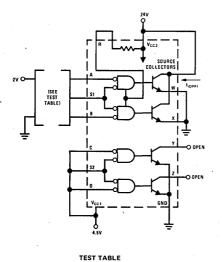
Note 5: Voltage values are with respect to network ground terminal.

Note 6: These parameters must be measured using pulse techniques,  $t_W = 200\mu s$ , duty cycle  $\leq 2\%$ .

# Switching Characteristics $(V_{CC1} = 5V, T_A = 25^{\circ}C)$

PARAMETER		COM	IDITIONS	MIN	TYP	MAX	UNITS
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High	$V_{CC2} = 15V, R_L = 24\Omega,$	Source Collectors		25	50	ns
	Level Output	C <sub>L</sub> = 25 pF, (Figure 9)	Sink Outputs		20	45	ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low	$V_{CC2}$ = 15V, $R_L$ = 24 $\Omega$ ,	Source Collectors		25	50	ns
	Level Output	C <sub>L</sub> = 25 pF, (Figure 9)	Sink Outputs		20	45	ns
t <sub>TLH</sub>	Transition Time, Low-to-High Level Output	C <sub>1</sub> = 25 pF	Source Outputs, $V_{CC2} = 20V$ , $R_L = 1 k\Omega$ , (Figure 10)		55		ns
	CL	С 25 рг	Sink Outputs, $V_{CC2} = 15V$ , $R_L = 24\Omega$ , (Figure 9)		7	15	ns
t <sub>THL</sub>	Transition Time, High-to-Low Level Output	C <sub>1</sub> = 25 pF	Source Outputs, $V_{CC2} = 20V$ , $R_L = 1 \text{ k}\Omega$ , (Figure 10)		7		ns
;	•	оլ – 25 рг	Sink Outputs, $V_{CC2} = 15V$ , $R_L = 24\Omega$ , (Figure 9)		9	20	ns
ts	Storage Time, Sink Outputs	$V_{CC2} = 15V, R_L = 24\Omega, C$	_ = 25 pF, ( <i>Figure 9</i> )		15	30	ns

# **DC Test Circuits**



A B S1 GND GND 2V

GND

4.5V O SSURGE COLLECTIONS

4.5V O SSURGE COLLECTIONS

4.5V O SSEE TEST TABLE)

D V O OPEN

4.5V O OPEN

4.5V O OPEN

4.5V O OPEN

4.5V O OPEN

4.5V O OPEN

4.5V O OPEN

4.5V O OPEN

4.5V O OPEN

5.00 OPEN

6.00 OPEN

6.00 OPEN

 C
 D
 S2
 Y
 Z

 2V
 4.5V
 GND
 V<sub>OH</sub>
 OPEN

 GND
 4.5V
 2V
 V<sub>OH</sub>
 OPEN

 4.5V
 2V
 GND
 OPEN
 V<sub>OH</sub>

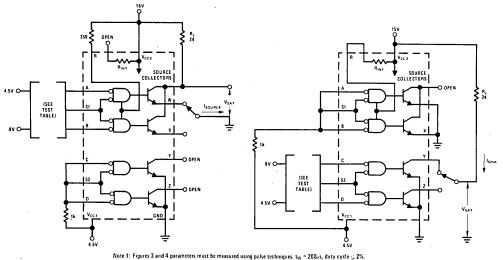
 4.5V
 GND
 2V
 OPEN
 V<sub>OH</sub>

TEST TABLE

FIGURE 1. IOFF

FIGURE 2.  $V_{IH}$  and  $V_{OH}$ 

# DC Test Circuits (Continued)

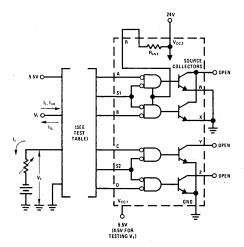


TEST TABLE									
Α	В	S1	w ·	х					
V8.0	4.5V	0.8V	GND	OPEN					
4.51/	0.81/	0.877	OPEN	CND					

FIGURE 3.  $V_{IL}$  and Source  $V_{SAT}$ 

TEST TABLE С D S2 z V8.0 4.5V OPEN V8.0 Rι 4.5V V8.0 V8.0 OPEN RL

FIGURE 4. VIL and Sink VSAT



 $\mathfrak{l}_{1},\mathfrak{l}_{1H}$ 

APPLY V <sub>I</sub> = 5.5V MEASURE I <sub>I</sub> APPLY V <sub>I</sub> = 2.4V MEASURE I <sub>IH</sub>	GROUND	APPLY 5.5V
Α	S1	B, C, S2, D
S1	A. B	C. S2. D

A, C, S2, D

С S2 A, S1, B, D C, D A, S1, B S2 S2 A, S1, B, C D

S1

S1

В

TEST TABLES

 $V_{\rm I}, I_{\rm IL}$ 

APPLY V <sub>I</sub> = 0.4V, MEASURE I <sub>IL</sub> APPLY I <sub>I</sub> = -10 mA, MEASURE V <sub>I</sub>	APPLY 5.5V		
Α	S1, B, C, S2, D		
S1	A, B, C, S2, D		
В	A, S1, C, S2, D		
С	A, S1, B, S2, D		
\$2	A, S1, B, C, D		
D	A, S1, B, C, S2		

FIGURE 5. VI, II, IIH, and IIL

# DC Test Circuits (Continued)

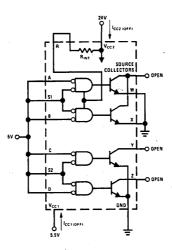


FIGURE 6. ICC1(OFF) and ICC2(OFF)

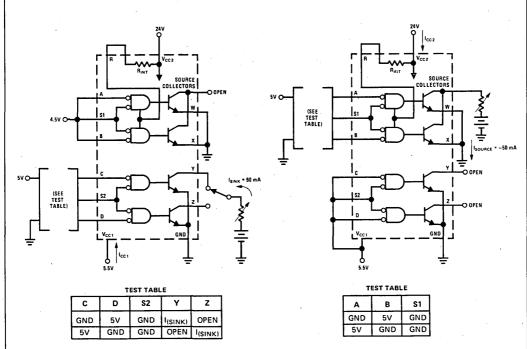
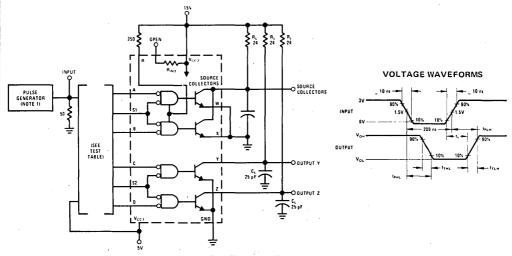


FIGURE 7. ICC1, Either Sink On

FIGURE 8. I<sub>CC2</sub>, Either Source On

#### DC Test Circuits (Continued)

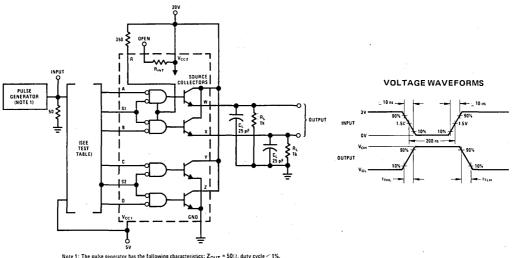


Note 1: The pulse generator has the following characteristics:  $Z_{OUT}$  = 50:2, duty cycle  $\leq$  1%. Note 2:  $C_L$  includes probe and jig capacitance.

TEST TABLE

PARAMETER	OUTPUT UNDER TEST	INPUT	CONNECT TO 5V
tp <sub>LH</sub> and tp <sub>HL</sub>		A and S1	B, C, D and S2
	Source collectors	B and S1	A, C, D and S2
tpLH, tpHL,	Sink output Y	C and S2	A, B, D and S1
t <sub>TLH</sub> , t <sub>THL</sub> , and t <sub>s</sub>	Sink output Z	D and S2	A, B, C and S1

FIGURE 9. Switching Times



Note 1: The pulse generator has the following characteristics:  $Z_{OUT}$  = 50:2, duty cycle  $\leq$  1%. Note 2:  $C_U$  includes probe and jig capacitance.

TEST TABLE

PARAMETER	OUTPUT UNDER TEST	INPUT	CONNECT TO 5V
tTLH and tTHL	Source output W	A and S1	B, C, D, and S2
TICH SHO THE	Source output X	B and S1	A, C, D, and S2

FIGURE 10. Transition Times of Source Outputs

#### **Applications**

#### **External Resistor Calculation**

A typical magnetic-memory word drive requirement is shown in Figure 11. A source-output transistor of one DS75325 delivers load current ( $I_L$ ). The sink-output transistor of another DS75325 sinks this current.

The value of the external pull-up resistor  $(R_{ext})$  for a particular memory application may be determined using the following equation:

$$R_{\text{ext}} = \frac{16 \left[ V_{\text{CC2(min)}} - V_{\text{S}} - 2.2 \right]}{I_{\text{L}} - 1.6 \left[ V_{\text{CC2(min)}} - V_{\text{S}} - 2.9 \right]} \tag{1}$$

where:  $R_{ext}$  is in  $k\Omega$ ,

 $V_{CC2\{min\}}$  is the lowest expected value of  $V_{CC2}$  in volts,  $V_S$  is the source output voltage in volts with respect to ground,  $I_L$  is in mA.

The power dissipated in resistor  $R_{\rm ext}$  during the load current pulse duration is calculated using Equation 2.

$$P_{\text{Rext}} \approx \frac{I_L}{16} \left[ V_{\text{CC2(min)}} - V_{\text{S}} - 2 \right]$$
 (2)

where: PRext is in mW.

After solving for  $R_{\text{ext}}$ , the magnitude of the source collector current ( $I_{\text{CS}}$ ) is determined from Equation 3.

$$I_{CS} \approx 0.94 I_{L} \tag{3}$$

where: I<sub>CS</sub> is in mA.

As an example, let  $V_{CC2(min)} = 20V$  and  $V_L = 3V$  while  $I_L$  of 500 mA flows. Using Equation 1:

$$R_{\text{ext}} = \frac{16 (20 - 3 - 2.2)}{500 - 1.6 (20 - 3 - 2.9)} = 0.5 \text{ k}\Omega$$

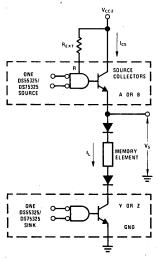
and from Equation 2:

$$P_{\text{Rext}} \approx \frac{500}{16} [20 - 3 - 2] \approx 470 \text{ mW}$$

The amount of the memory system current source ( $I_{CS}$ ) from Equation 3 is:

$$I_{CS} \approx 0.94 (500) \approx 470 \text{ mA}$$

In this example the regulated source-output transistor base current through the external pull-up resistor ( $R_{ext}$ ) and the source gate is approximately 30 mA. This current and  $I_{CS}$  comprise  $I_{L}$ .



Note 1: For clarity, partial logic diagrams of two DS55325's are shown.

Note 2: Source and sink shown are in different packages.

FIGURE 11. Typical Application Data



# **DS75361 Dual TTL-to-MOS Driver**

# **General Description**

The DS75361 is a monolithic integrated dual TTL-to-MOS driver interface circuit. The device accepts standard TTL input signals and provides high-current and high-voltage output levels for driving MOS circuits. It is used to drive address, control, and timing inputs for several types of MOS RAMs including the 1103 and MM5270 and MM5280.

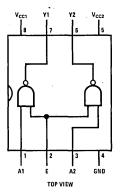
The DS75361 operates from standard TTL 5V supplies and the MOS  $V_{SS}$  supply in many applications. The device has been optimized for operation with  $V_{CC2}$  supply voltage from 16V to 20V; however, it is designed for use over a much wider range of  $V_{CC2}$ .

## **Features**

- Capable of driving high-capacitance loads
- Compatible with many popular MOS RAMs
- V<sub>CC2</sub> supply voltage variable over wide range to 24V
- Diode-clamped inputs
- TTL compatible
- Operates from standard bipolar and MOS supplies
- High-speed switching
- Transient overdrive minimizes power dissipation
- Low standby power dissipation

# **Connection Diagram**

#### Dual-In-Line Package



Order Number DS75361J-8 or DS75361N See NS Package J08A or N08A

#### Absolute Maximum Ratings (Note 1) **Operating Conditions** UNITS MAX Supply Voltage Range of V<sub>CC1</sub> (Note 1) -0.5V to 7V Supply Voltage (VCC1) 4.75 5.25 Supply Voltage (V<sub>CC2</sub>) Supply Voltage Range of V<sub>CC2</sub> -0.5V to 25V 4.75 24 v Input Voltage 5.5V °c

300°C

Operating Temperature (TA)

+70

Inter-Input Voltage (Note 4) 5.5V Storage Temperature Range -65°C to +150°C Maximum Power Dissipation\* at 25°C Molded Package 1022 mW

Lead Temperature 1/16 Inch from Case for 60 Seconds: J Package

Lead Temperature 1/16 Inch from Case for 200°C 10 Seconds: N or P Package

\*Derate molded package 8.2 mW/°C above 25°C.

#### **Electrical Characteristics** (Notes 2 and 3)

PARAMETER		COND	CONDITIONS		TYP	MAX	UNITS
VIH	High Level Input Voltage						V
V,L	Low-Level Input Voltage					0.8	V
V <sub>1</sub>	Input Clamp Voltage	I <sub>1</sub> = -12 mA				-1.5	V
V <sub>ОН</sub>	High-Level Output Voltage	V <sub>IL</sub> = 0.8V, I <sub>OH</sub> V <sub>IL</sub> = 0.8V, I <sub>OH</sub>			V <sub>CC2</sub> -0.7 V <sub>CC2</sub> -1.8		V
VoL	Low-Level Output Voltage	V <sub>IH</sub> = 2V, I <sub>OL</sub>			0.15	0.3	٧
		$V_{CC2} = 15V \text{ to}$ $I_{OL} = 40 \text{ mA}$	24V, V <sub>IH</sub> = 2V,		0.25	0.5	V
V <sub>O</sub>	Output Clamp Voltage	V <sub>I</sub> = 0V, I <sub>OH</sub> =	V <sub>1</sub> = 0V, I <sub>OH</sub> = 20 mA			V <sub>CC2</sub> +1.5	V
I <sub>1</sub>	Input Current at Maximum Input Voltage	V <sub>1</sub> = 5.5V	V <sub>1</sub> = 5.5V			1	mA
I <sub>IH</sub>	High-Level Input Current	V <sub>1</sub> = 2.4V	A Inputs			40	μΑ
			E Input			80	μΑ
IIL	Low-Level Input Current	V <sub>1</sub> = 0.4V	A Inputs E Input		1 -2	-1.6 -3.2	mA mA
I <sub>CC1(H)</sub>	Supply Current from V <sub>CC1</sub> , Both Outputs High	V <sub>CC1</sub> = 5.25V,	V <sub>CC2</sub> = 24V,		2	4	mA
I <sub>CC2(H)</sub>	Supply Current from V <sub>CC2</sub> , Both Outputs High	All Inputs at 0V	All Inputs at OV, No Load			0.5	m A
I <sub>CC1(L)</sub>	Supply Current from V <sub>CC1</sub> , Both Outputs Low	V <sub>CC1</sub> = 5.25V,			16	24	mA
I <sub>CC2(L)</sub>	Supply Current from V <sub>CC2</sub> , Both Outputs Low	All Inputs at 5\	, No Load		7	11	mA
I <sub>CC2(S)</sub>	Supply Current from V <sub>CC2</sub> , Stand-by Condition	V <sub>CC1</sub> = 0V, All Inputs at 5\	-			0.5	mΑ

# Switching Characteristics

 $(V_{CC1} = 5V, V_{CC2} = 20V, T_A = 25^{\circ}C)$ 

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>DLH</sub>	Delay Time, Low-to-High Level Output			11	20	ns
t <sub>DHL</sub>	Delay Time, High-to-Low Level Output			10	18	ns
t <sub>TLH</sub>	Transition Time, Low-to-High Level Output	$C_L = 390  pF,$ $R_D = 10\Omega$		25	40	ns
t <sub>THL</sub>	Transition Time, High-to-Low Level Output	(Figure 1)		21	35	ns
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High Level Output		10	36	55	ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low Level Output		10	31	47	ns

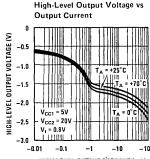
Note 1: "Absolute Maximum Ratings" are those values beyond, which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

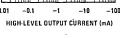
Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range for the DS75361. All typical values are for TA = 25°C and  $V_{CC1} = 5V$  and  $V_{CC2} = 20V$ .

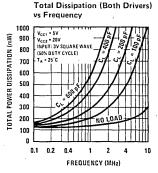
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: This rating applies between the A input of either driver and the common E input.

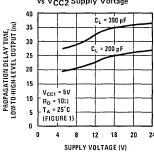
# **Typical Performance Characteristics**



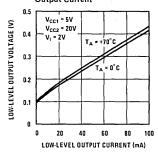




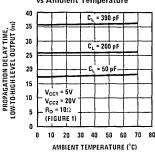
Propagation Delay Time, Low-to-High Level Output vs V<sub>CC2</sub> Supply Voltage



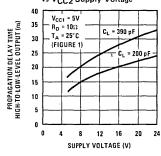
Low-Level Output Voltage vs **Output Current** 



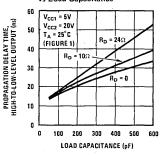
Propagation Delay Time, Low-to-High Level Output vs Ambient Temperature



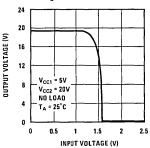
Propagation Delay Time, High-to-Low Level Output vs V<sub>CC2</sub> Supply Voltage



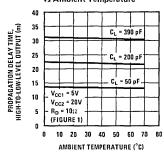
#### Propagation Delay Time, High-to-Low Level Output vs Load Capacitance



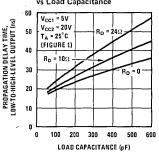
Voltage Transfer Characteristics



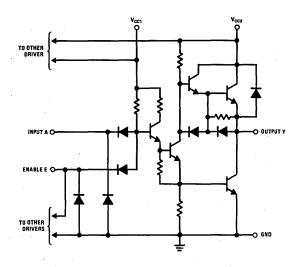
Propagation Delay Time, High-to-Low Level Output vs Ambient Temperature



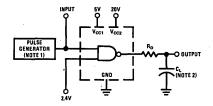
Propagation Delay Time, Low-to-High Level Output vs Load Capacitance

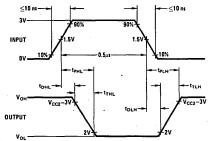


# Schematic Diagram (1/2 shown)



# AC Test Circuit and Switching Time Waveforms





Note 1: The pulse generator has the following characteristics: PRR = 1 MHz,  $Z_{OUT}\approx 50\Omega$ . Note 2:  $C_L$  includes probe and jig capacitance.

FIGURE 1. Switching Times, Each Driver

# **Typical Applications**

The fast switching speeds of this device may produce undesirable output transient overshoot because of load or wiring inductance. A small series damping resistor may be used to reduce or eliminate this output transient

overshoot. The optimum value of the damping resistor to use depends on the specific load characteristics and switching speed. A typical value would be between  $10\Omega$  and  $30\Omega$  (Figure 3).

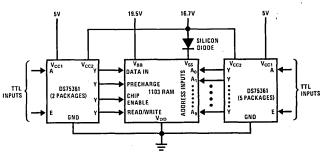


FIGURE 2. Interconnection of DS75361 Devices with 1103 RAM

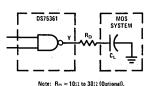


FIGURE 3. Use of Damping Resistor to Reduce or Eliminate Output Transient Overshoot in Certain DS75361 Applications

## Thermal Information

#### POWER DISSIPATION PRECAUTIONS

Significant power may be dissipated in the DS75361 driver when charging and discharging high-capacitance loads over a wide voltage range at high frequencies. The total dissipation curve shows the power dissipated in a typical DS75361 as a function of load capacitance and frequency. Average power dissipated by this driver can be broken into three components:

$$P_{T(AV)} = P_{DC(AV)} + P_{C(AV)} + P_{S(AV)}$$

where  $P_{DC(AV)}$  is the steady-state power dissipation with the output high or low,  $P_{C(AV)}$  is the power level during charging or discharging of the load capacitance, and  $P_{S(AV)}$  is the power dissipation during switching between the low and high levels. None of these include energy transferred to the load and all are averaged over a full cycle.

The power components per driver channel are:

$$\begin{split} P_{DC(AV)} &= \frac{p_L t_L + p_H t_H}{T} \\ P_{C(AV)} &\approx C \ V_C^2 \ f \\ P_{S(AV)} &= \frac{p_L + t_L + p_H t_H}{T} \end{split}$$

where the times are as defined in Figure 4.

 $p_L,\,p_H,\,p_{LH},$  and  $p_{HL}$  are the respective instantaneous levels of power dissipation and C is load capacitance.

The DS75361 is so designed that  $P_S$  is a negligible portion of  $P_T$  in most applications. Except at very high frequencies,  $t_L + t_H >> t_{LH} + t_{HL}$  so that  $P_S$  can be

neglected. The total dissipation curve for no load demonstrates this point. The power dissipation contributions from both channels are then added together to obtain total device power.

The following example illustrates this power calculation technique. Assume both channels are operating identically with C = 200 pF, f = 2 MHz,  $V_{\rm CC1}$  = 5V,  $V_{\rm CC2}$  = 20V, and duty cycle = 60% outputs high (t<sub>H</sub>/T = 0.6). Also, assume  $V_{\rm OH}$  = 19.3V,  $V_{\rm OL}$  = 0.1V,  $P_{\rm S}$  is negligible, and that the current from  $V_{\rm CC2}$  is negligible when the output is high.

On a per-channel basis using data sheet values:

$$P_{DC(AV)} = \left[ (5V) \left( \frac{2 \text{ mA}}{2} \right) + (20V) \left( \frac{0 \text{ mA}}{2} \right) \right] (0.6) + \left[ (5V) \left( \frac{16 \text{ mA}}{2} \right) + (20V) \left( \frac{7 \text{ mA}}{2} \right) \right] (0.4)$$

PDC(AV) = 47 mW per channel

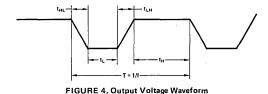
$$P_{C(AV)} \approx (200 \text{ pF}) (19.2 \text{V})^2 (2 \text{ MHz})$$

P<sub>C(AV)</sub> ≈ 148 mW per channel.

For the total device dissipation of the two channels:

$$P_{T(\Delta V)} \approx 2 (47 + 148)$$

P<sub>T(AV)</sub> ≈ 390 mW typical for total package.



6-77

# National Semiconductor

# **Memory Support**

# DS75362 Dual TTL-to-MOS Driver

# **General Description**

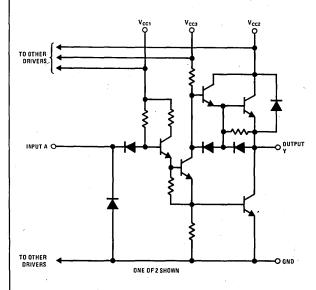
The DS75362 is a dual monolithic integrated TTL-to-MOS driver and interface circuit that accepts standard TTL input signals and provides high-current and high-voltage output levels suitable for driving MOS circuits. It is used to drive address, control, and timing inputs for several types of MOS RAMs including the 1103.

The DS75362 operates from the TTL 5V supply and the MOS  $V_{SS}$  and  $V_{BB}$  supplies in many applications. This device has been optimized for operation with  $V_{CC2}$  supply voltage from 16V to 20V, and with nominal  $V_{CC3}$  supply voltage from 3V to 4V higher than  $V_{CC2}$ . However, it is designed so as to be usable over a much wider range of  $V_{CC2}$  and  $V_{CC3}$ . In some applications the  $V_{CC3}$  power supply can be eliminated by connecting the  $V_{CC3}$  pin to the  $V_{CC2}$  pin.

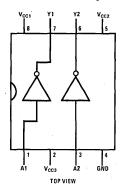
#### **Features**

- Dual positive-logic NAND TTL-to-MOS driver
- Versatile interface circuit for use between TTL and high-current, high-voltage systems
- Capable of driving high-capacitance loads
- Compatible with many popular MOS RAMs
- V<sub>CC2</sub> supply voltage variable over wide range to 24V maximum
- V<sub>CC3</sub> supply voltage pin available
- V<sub>CC3</sub> pin can be connected to V<sub>CC2</sub> pin in some applications
- TTL compatible diode-clamped inputs
- Operates from standard bipolar and MOS supply voltages
- High-speed switching
- Transient overdrive minimizes power dissipation
- Low standby power dissipation

# **Schematic and Connection Diagrams**



Dual-In-Line Package



Order Number DS75362J-8 or DS75362N See NS Package J08A or N08A

Absolute Maximum Rati	Operating Conditions						
		•	MIN	MAX	UNITS		
Supply Voltage Range of V <sub>CC1</sub>	-0.5V to 7V	Supply Voltage (VCC1)	4.75	5.25	V		
Supply Voltage Range of V <sub>CC2</sub>	-0.5V to 25V	Supply Voltage (VCC2)	4.75	24	٧		
Supply Voltage Range of V <sub>CC3</sub>	-0.5V to 30V	Supply Voltage (VCC3)	V <sub>CC2</sub>	28	V		
Input Voltage Inter-Input Voltage (Note 4) Storage Temperature Range	5.5V 5.5V –65°C to +150°C	Voltage Difference Between Supply Voltages: VCC3-VCC2	0	10	<b>v</b>		
Maximum Power Dissipation* at 25°C Molded Package Lead Temperature (Soldering, 10 seconds)	1022 mW 300°C	Operating Ambient Temperature Range (T <sub>A</sub> )	0	70	°c		

<sup>\*</sup>Derate molded package 8.2 mW/ $^{\circ}$ C above 25 $^{\circ}$ C.

# Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>IH</sub>	High-Level Input Voltage		2			V
VIL	Low-Level Input Voltage				0.8	V
V <sub>I</sub>	Input Clamp Voltage	I <sub>I</sub> = -12 mA			-1.5	
V <sub>он</sub>	High-Level Output Voltage	$V_{CC3} = V_{CC2} + 3V$ , $V_{IL} = 0.8V$ , $I_{OH} = -100\mu A$	V <sub>CC2</sub> -0.3	V <sub>CC2</sub> -0.1		V
		$V_{CC3} = V_{CC2} + 3V$ , $V_{1L} = 0.8V$ , $I_{OH} = -10 \text{ mA}$		V <sub>CC2</sub> -0.9		
		$V_{CC3} = V_{CC2}, V_{IL} = 0.8V, I_{OH} = -50\mu A$	V <sub>CC2</sub> -1	V <sub>CC2</sub> -0.7		v
	<u>.</u>	$V_{CC3} = V_{CC2}, V_{IL} = 0.8V, I_{OH} = -10 \text{ mA}$	V <sub>CC2</sub> -2.3	V <sub>CC2</sub> -1.8		V
VoL	Low-Level Output Voltage	V <sub>IH</sub> = 2V, I <sub>OL</sub> = 10 mA		0.15	0.3	v
		$V_{CC3} = 15V \text{ to } 28V, V_{1H} = 2V, I_{OL} = 40 \text{ mA}$		0.25	0.5	V
V <sub>o</sub>	Output Clamp Voltage	V <sub>I</sub> = 0V, I <sub>OH</sub> = 20 mA			V <sub>CC2</sub> +1.5	
l <sub>1</sub>	Input Current at Maximum Input Voltage	V <sub>1</sub> = 5.5V			1	mA
l <sub>iH</sub>	High-Level Input Current	V <sub>1</sub> = 2.4V			40	μΑ
I <sub>IL</sub>	Low-Level Input Current	V <sub>1</sub> = 0.4V		-1	-1.6	m <i>P</i>
I <sub>CC1(H)</sub>	Supply Current from V <sub>CC1</sub> , All Outputs High			2	4	mA
I <sub>CC2(H)</sub>	Supply Current from V <sub>CC2</sub> ,	V <sub>CC1</sub> = 5.25V, V <sub>CC2</sub> = 24V,		-1.1	+0.25	m.A
	All Outputs High	V <sub>CC3</sub> = 28V, All Inputs at 0V, No Load		-1.1	-1.6	m/
I <sub>CC3(H)</sub>	Supply Current from $V_{CC3}$ , All Outputs High			1.1	1.8	m <i>P</i>
I <sub>CC1(L)</sub>	Supply Current from V <sub>CC1</sub> , All Outputs Low			15	23.5	m.F
I <sub>CC2(L)</sub>	Supply Current from V <sub>CC2</sub> , All Outputs Low	$V_{CC1} = 5.25V, V_{CC2} = 24V,$ $V_{CC3} = 28V, All Inputs at 5V, No Load$			1.5	m <i>P</i>
I <sub>CC3(L)</sub>	Supply Current from V <sub>CC3</sub> , All Outputs Low			8	12.5	m <i>A</i>
I <sub>CC2(H)</sub>	Supply Current from V <sub>CC2</sub> , All Outputs High	V <sub>CC1</sub> = 5.25V, V <sub>CC2</sub> = 24V,			0.25	m <i>P</i>
I <sub>CC3(H)</sub>	Supply Current from V <sub>CC3</sub> , All Outputs High	V <sub>CC3</sub> = 24V, All Inputs at OV, No Load			0.5	, mA
I <sub>CC2(S)</sub>	Supply Current from V <sub>CC2</sub> , Stand-by Condition	V <sub>CC1</sub> = 0V, V <sub>CC2</sub> = 24V,			0.25	m <i>A</i>
I <sub>CC3(S)</sub>	Supply Current from V <sub>CC3</sub> , Stand-by Condition	V <sub>CC3</sub> = 24V, All Inputs at 5V, No Load		i	0.5	m/

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C range for the DS75362. All typical values are for T<sub>A</sub> = 25°C and V<sub>CC1</sub> = 5V and V<sub>CC2</sub> = 20V and V<sub>CC3</sub> = 24V.

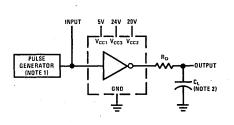
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

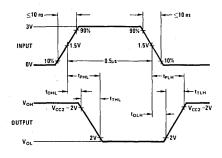
Note 4: This rating applies between any two inputs of any one of the gates.

# Switching Characteristics $(V_{CC1} = 5V, V_{CC2} = 20V, V_{CC3} = 24V, T_A = 25^{\circ}C)$

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>DLH</sub>	Delay Time, Low-to-High Level Output			11	20	ns
t <sub>DHL</sub>	Delay Time, High-to-Low Level Output			10	18	ns
tTLH	Transition Time, Low-to-High Level Output	$C_L = 200 pF$ , $R_D = 24\Omega$ ,		20	33	ns
t <sub>THL</sub>	Transition Time, High-to-Low Level Output	(Figure 1)		20	33	ns
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High Level Output		10	31	48 -	ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low Level Output		10	30	46	ns

# **AC Test Circuit and Switching Time Waveforms**

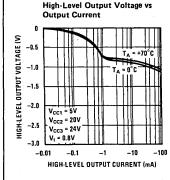


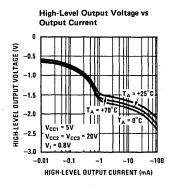


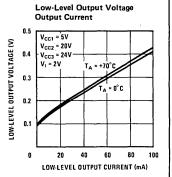
Note 1: The pulse generator has the following characteristics: PRR = 1 MHz,  $Z_{OUT}\approx 50\Omega$ . Note 2:  $C_L$  includes probe and jig capacitance.

FIGURE 1. Switching Times, Each Driver

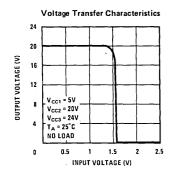
# **Typical Performance Characteristics**

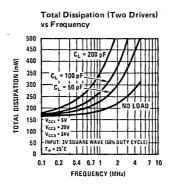


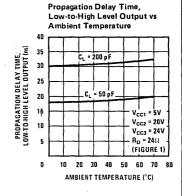


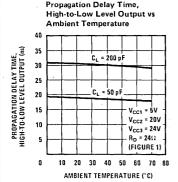


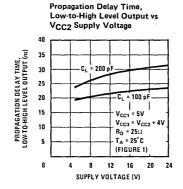
## Typical Performance Characteristics (Continued)

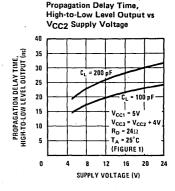


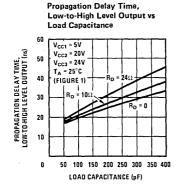


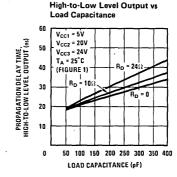








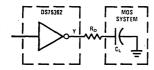




Propagation Delay Time,

# **Typical Application**

The fast switching speeds of this device may produce undesirable output transient overshoot because of load or wiring inductance. A small series damping resistor may be used to reduce or eliminate this output transient overshoot. The optimum value of the damping resistor depends on the specific load characteristics and switching speed. A typical value would be between  $10\Omega$  and  $30\Omega$  (Figure 2).



Note:  $R_D\approx 10\Omega$  to  $30\Omega$  (Optional).

FIGURE 2. Use of Damping Resistor to Reduce or Eliminate Output Transient Overshoot In Certain DS75362 Applications.

### Thermal Information

#### POWER DISSIPATION PRECAUTIONS

Significant power may be dissipated in the DS75362 driver when charging and discharging high-capacitance loads over a wide voltage range at high frequencies. The total dissipation curve shows the power dissipated in a typical DS75362 as a function of load capacitance and frequency. Average power dissipation by this driver can be broken into three components:

$$P_{T(AV)} = P_{DC(AV)} + P_{C(AV)} + P_{S(AV)}$$

where  $P_{DC(AV)}$  is the steady-state power dissipation with the output high or low,  $P_{C(AV)}$  is the power level during charging or discharging of the load capacitance, and  $P_{S(AV)}$  is the power dissipation during switching between the low and high levels. None of these include energy transferred to the load and all are averaged over a full cycle.

The power components per driver channel are:

$$\begin{split} P_{DC(AV)} &= \frac{p_L t_L + p_H t_H}{T} \\ P_{C(AV)} &\approx C \ V_C^2 \ f \\ \\ P_{S(AV)} &= \frac{p_{LH} t_{LH} + p_{HL} t_{HL}}{T} \end{split}$$

where the times are as defined in Figure 3.

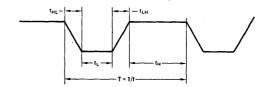


FIGURE 3. Output Voltage Waveform

p<sub>L</sub>, p<sub>H</sub>, p<sub>LH</sub>, and p<sub>HL</sub> are the respective instantaneous levels of power dissipation and C is load capacitance.

The DS75362 is so designed that  $P_S$  is a negligible portion of  $P_T$  in most applications. Except at very high frequencies,  $t_L + t_H >> t_{LH} + t_{HL}$  so that  $P_S$  can be neglected. The total dissipation curve for no load demonstrates this point. The power dissipation contributions from two channels are then added together to obtain total device power.

The following example illustrates this power calculation technique. Assume two channels are operating identically with C = 100 pF, f = 2 MHz,  $V_{\rm CC1}$  = 5V,  $V_{\rm CC2}$  = 20V,  $V_{\rm CC3}$  = 24V and duty cycle = 60% outputs high (t<sub>H</sub>/T = 0.6). Also, assume  $V_{\rm OH}$  = 20V,  $V_{\rm OL}$  = 0.1V,  $P_{\rm S}$  is negligible, and that the current from  $V_{\rm CC2}$  is negligible when the output is low.

On a per-channel basis using data sheet values:

$$P_{DC(AV)} = \left[ (5V \left( \frac{4 \text{ mA}}{4} \right) + (20V) \left( \frac{-2.2 \text{ mA}}{4} \right) + (24V) \left( \frac{2.2 \text{ mA}}{4} \right) \right] + (24V) \left( \frac{31 \text{ mA}}{4} \right) + (24V) \left( \frac{31 \text{ mA}}{4} \right) + (24V) \left( \frac{16 \text{ mA}}{4} \right) \right] (0.4)$$

PDC(AV) = 58 mW per channel

$$P_{C(AV)} \approx (100 \text{ pF}) (19.9 \text{V})^2 (2 \text{ MHz})$$

P<sub>C(AV)</sub> ≈ 79 mW per channel.

For the total device dissipation of the two channels

$$P_{T(AV)} \approx 2 (58 + 79)$$

 $P_{T(AV)} \approx 274$  mW typical for total package.

# **Memory Support**

# DS75365 Quad TTL-to-MOS Driver

# **General Description**

The DS75365 is a quad monolithic integrated TTL-to-MOS driver and interface circuit that accepts standard TTL input signals and provides high-current and high-voltage output levels suitable for driving MOS circuits. It is used to drive address, control, and timing inputs for several types of MOS RAMs including the 1103.

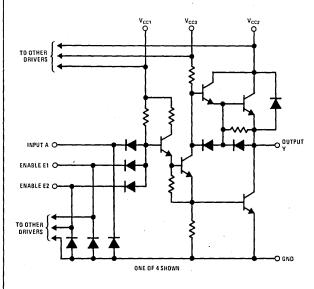
The DS75365 operates from the TTL 5V supply and the MOS  $V_{SS}$  and  $V_{BB}$  supplies in many applications. This device has been optimized for operation with  $V_{CC2}$  supply voltage from 16V to 20V, and with nominal  $V_{CC3}$  supply voltage from 3V to 4V higher than  $V_{CC2}$ . However, it is designed so as to be usable over a much wider range of  $V_{CC2}$  and  $V_{CC3}$ . In some applications the  $V_{CC3}$  power supply can be eliminated by connecting the  $V_{CC3}$  pin to the  $V_{CC2}$  pin.

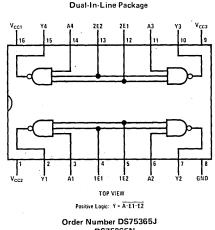
#### **Features**

- Quad positive-logic NAND TTL-to-MOS driver
- Versatile interface circuit for use between TTL and high-current, high-voltage systems

- Capable of driving high-capacitance loads
- Compatible with many popular MOS RAMs
- Interchangeable with Intel 3207
- V<sub>CC2</sub> supply voltage variable over wide range to 24V maximum
- V<sub>CC3</sub> supply voltage pin available
- V<sub>CC3</sub> pin can be connected to V<sub>CC2</sub> pin in some applications
- TTL compatible diode-clamped inputs
- Operates from standard bipolar and MOS supply voltages
- Two common enable inputs per gate-pair
- High-speed switching
- Transient overdrive minimizes power dissipation
- Low standby power dissipation

# **Schematic and Connection Diagrams**





Order Number DS75365J or DS75365N See NS Package J16A or N16A

# Absolute Maximum Ratings (Note 1)

 Supply Voltage Range of V<sub>CC1</sub>
 -0.5V to 7V

 Supply Voltage Range of V<sub>CC2</sub>
 -0.5V to 25V

 Supply Voltage Range of V<sub>CC3</sub>
 -0.5V to 30V

 Input Voltage
 5.5V

 Inter-Input Voltage (Note 4)
 5.5V

-65°C to +150°C

1509 mW

1476 mW

300° C

Storage Temperature Range
Maximum Power Dissipation\* at 25°C
Cavity Package

Molded Package Lead Temperature (Soldering, 10 seconds) **Operating Conditions** 

MIN 4.75 UNITS MAX Supply Voltage (V<sub>CC1</sub>) 5.25 Supply Voltage (VCC2) 4.75 24 Supply Voltage (VCC3) 28 v V<sub>CC2</sub> Voltage Difference Between 10 Supply Voltages: VCC3-VCC2 °c Operating Ambient Temperature 70

Range (TA)

\*Derate cavity package 10.1 mW/° C above 25° C; derate molded package 11.8 mW/° C above 25° C.

Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
V <sub>IH</sub>	High-Level Input Voltage			2			V
V <sub>I</sub> L	Low-Level Input Voltage					0.8	V
V <sub>t</sub>	Input Clamp Voltage	I <sub>1</sub> = -12 mA	· · · · · · · · · · · · · · · · · · ·	<del> </del>		-1.5	v
V <sub>OH</sub> .	High-Level Output Voltage	Vcca = Vcca+3\	$V_{1L} = 0.8V, I_{OH} = -100\mu A$	Vcc2-0.3	V <sub>CC2</sub> -0.1		V
OH .			$V_1$ , $V_{1L} = 0.8V$ , $I_{OH} = -10 \text{ mA}$	V <sub>CC2</sub> -1.2			V
			<sub>IL</sub> = 0.8V, I <sub>OH</sub> = -50μA	V <sub>CC2</sub> -1	V <sub>CC2</sub> -0.7		V
	.*		<sub>IL</sub> = 0.8V, I <sub>OH</sub> = -10 mA	V <sub>CC2</sub> -2.3			V
VoL	Low-Level Output Voltage	V <sub>IH</sub> = 2V, I <sub>OL</sub> =	10 mA	†	0.15	0.3	V
	• ,	V <sub>CC3</sub> = 15V to 2	8V, V <sub>IH</sub> = 2V, I <sub>OL</sub> = 40 mA	1	0.25	0.5	٧
Vo	Output Clamp Voltage	V <sub>1</sub> = 0V, I <sub>OH</sub> = 2	20 mA			V <sub>CC2</sub> +1.5	V
l <sub>1</sub>	Input Current at Maximum Input Voltage	V <sub>1</sub> = 5.5V				1	mA
I <sub>IH</sub>	High-Level Input Current		A Inputs			40	μΑ
		V <sub>1</sub> = 2.4V	E1 and E2 Inputs			80	μΑ
I <sub>IL</sub>	Low-Level Input Current	V <sub>1</sub> = 0.4V	A Inputs	1	1	-1,6	mA
			E1 and E2 Inputs		-2	-3.2	mA
I <sub>CC1(H)</sub>	Supply Current from V <sub>CC1</sub> , All Outputs High	•			4	8	mA
I <sub>CC2(H)</sub>	Supply Current from V <sub>CC2</sub> , All Outputs High	V <sub>CC1</sub> = 5.25V, V V <sub>CC3</sub> = 28V, AII	$V_{CC2} = 24V$ , Inputs at 0V, No Load		-2.2 -2.2	+0.25 -3.2	mA mA
I <sub>CC3(H)</sub>	Supply Current from V <sub>CC3</sub> , All Outputs High				2.2	3.5	mA
I <sub>CC1(L)</sub>	Supply Current from V <sub>CC1</sub> , All Outputs Low		-		31	47	mA
I <sub>CC2(L)</sub>	Supply Current from V <sub>CC2</sub> , All Outputs Low	V <sub>CC1</sub> = 5.25V, V V <sub>CC3</sub> = 28V, All	CC2 = 24V, Inputs at 5V, No Load			3	mA
I <sub>CC3(L)</sub>	Supply Current from V <sub>CC3</sub> , All Outputs Low				. 16	25	mA
I <sub>CC2(H)</sub>	Supply Current from V <sub>CC2</sub> , All Outputs High	V <sub>CC1</sub> = 5.25V, \	V <sub>CC1</sub> = 5.25V, V <sub>CC2</sub> = 24V, V <sub>CC3</sub> = 24V, All Inputs at 0V, No Load			0.25	mA
I <sub>CC3(H)</sub>	Supply Current from V <sub>CC3</sub> , All Outputs High					0.5	mA
I <sub>CC2(S)</sub>	Supply Current from V <sub>CC2</sub> , Stand-by Condition	V <sub>CC1</sub> = 0V, V <sub>CC</sub>	<sub>2</sub> = 24V,			0.25	mA
I <sub>CC3(S)</sub>	Supply Current from V <sub>CC3</sub> , Stand-by Condition		Inputs at 5V, No Load			0.5	mA

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DS75365. All typical values are for  $T_{A} = 25^{\circ}$ C and  $V_{CC1} = 5V$  and  $V_{CC2} = 20V$  and  $V_{CC3} = 24V$ .

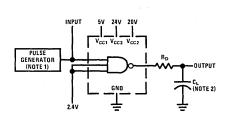
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

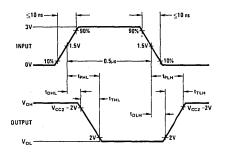
Note 4: This rating applies between any two inputs of any one of the gates.

# Switching Characteristics ( $V_{CC1}$ = 5V, $V_{CC2}$ = 20V, $V_{CC3}$ = 24V, $T_A$ = 25°C)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t <sub>DLH</sub> Delay Time, Low-to-High Level Output				11	20	ns
tont	Delay Time, High-to-Low Level Output	'		10	18	ns
t <sub>TLH</sub>	Transition Time, Low-to-High Level Output	$C_L = 200 \text{ pF},$ $R_D = 24\Omega,$		20	33	ns
t <sub>THL</sub>	Transition Time, High-to-Low Level Output	(Figure 1)		20	33	ns
t <sub>PLH</sub>	Propagation Delay Time, Low-to-High Level Output		10	31	48	ns
t <sub>PHL</sub>	Propagation Delay Time, High-to-Low Level Output		10	30	46	ns

# AC Test Circuit and Switching Time Waveforms

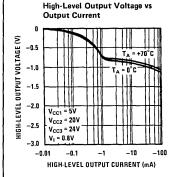


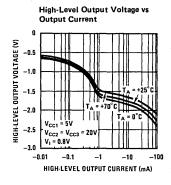


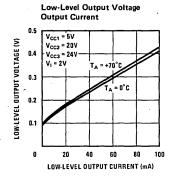
Note 1: The pulse generator has the following characteristics: PRR = 1 MHz,  $Z_{OUT}\approx50\Omega$ . Note 2:  $C_L$  includes probe and jig capacitance.

FIGURE 1. Switching Times, Each Driver

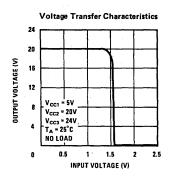
# **Typical Performance Characteristics**

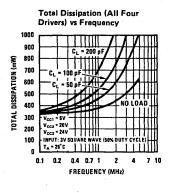


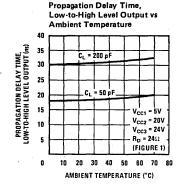


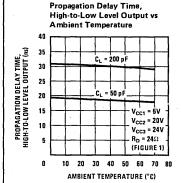


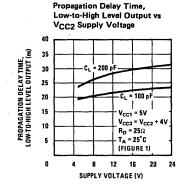
# Typical Performance Characteristics (Continued)

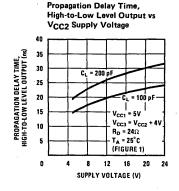


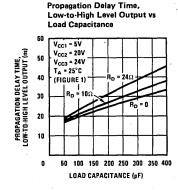


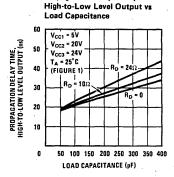












Propagation Delay Time,

# **Typical Applications**

The fast switching speeds of this device may produce undesirable output transient overshoot because of load or wiring inductance. A small series damping resistor may be used to reduce or eliminate this output transient

overshoot. The optimum value of the damping resistor depends on the specific load characteristics and switching speed. A typical value would be between 10 $\Omega$  and 30 $\Omega$  (Figure 3).

## Typical Applications (Continued)

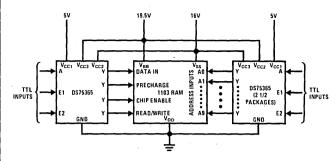


FIGURE 2. Interconnection of DS75365 Devices With 1103-Type Silicon-Gate MOS RAM

# DS75365 MOS SYSTEM $R_0$ $C_L$ Note: $R_0 \approx 1012$ to 3012 (Optional).

FIGURE 3. Use of Damping Resistor to Reduce or Eliminate Output Transient Overshoot In Certain DS75365 Applications

# Thermal Information

#### POWER DISSIPATION PRECAUTIONS

Significant power may be dissipated in the DS75365 driver when charging and discharging high-capacitance loads over a wide voltage range at high frequencies. The total dissipation curve shows the power dissipated in a typical DS75365 as a function of load capacitance and frequency. Average power dissipation by this driver can be broken into three components:

$$P_{T(AV)} = P_{DC(AV)} + P_{C(AV)} + P_{S(AV)}$$

where  $P_{DC(AV)}$  is the steady-state power dissipation with the output high or low,  $P_{C(AV)}$  is the power level during charging or discharging of the load capacitance, and  $P_{S(AV)}$  is the power dissipation during switching between the low and high levels. None of these include energy transferred to the load and all are averaged over a full cycle.

The power components per driver channel are:

$$P_{DC(AV)} = \frac{p_L t_L + p_H t_H}{T}$$

$$P_{C(\Delta V)} \approx C V_C^2 f$$

$$P_{S(AV)} = \frac{p_{LH}t_{LH} + p_{HL}t_{HL}}{T}$$

where the times are as defined in Figure 4.

 $p_L$ ,  $p_H$ ,  $p_{LH}$ , and  $p_{HL}$  are the respective instantaneous levels of power dissipation and C is load capacitance.

The DS75365 is so designed that  $P_S$  is a negligible portion of  $P_T$  in most applications. Except at very high frequencies,  $t_L + t_H >>> t_{LH} + t_{HL}$  so that  $P_S$  can be

neglected. The total dissipation curve for no load demonstrates this point. The power dissipation contributions from all four channels are then added together to obtain total device power.

The following example illustrates this power calculation technique. Assume all four channels are operating identically with C = 100 pF, f = 2 MHz,  $V_{\rm CC1}$  = 5V,  $V_{\rm CC2}$  = 20V,  $V_{\rm CC3}$  = 24V and duty cycle = 60% outputs high (t<sub>H</sub>/T = 0.6). Also, assume  $V_{\rm OH}$  = 20V,  $V_{\rm OL}$  = 0.1V,  $P_{\rm S}$  is negligible, and that the current from  $V_{\rm CC2}$  is negligible when the output is low.

On a per-channel basis using data sheet values:

$$P_{DC(AV)} = \left[ (5V \left( \frac{4 \text{ mA}}{4} \right) + (20V) \left( \frac{-2.2 \text{ mA}}{4} \right) + (24V) \left( \frac{31 \text{ mA}}{4} \right) + (24V) \left( \frac{31 \text{ mA}}{4} \right) + (20V) \left( \frac{0 \text{ mA}}{4} \right) + (24V) \left( \frac{16 \text{ mA}}{4} \right) \right] (0.4)$$

P<sub>DC(AV)</sub> = 58 mW per channel

$$P_{C(AV)} \approx (100 \text{ pF}) (19.9 \text{V})^2 (2 \text{ MHz})$$

P<sub>C(AV)</sub> ≈ 79 mW per channel.

For the total device dissipation of the four channels:

$$P_{T(\Delta V)} \approx 4 (58 + 79)$$

 $P_{T(AV)} \approx 548 \text{ mW typical for total package.}$ 

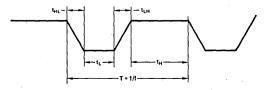


FIGURE 4. Output Voltage Waveform

# Applying Modern Clock Drivers to MOS Memories

National Semiconductor Application Note 76 B. Siegel M. Scott October 1975



#### INTRODUCTION

MOS memories present unique system and circuit challenges to the engineer since they require precise timing of input wave forms. Since these inputs present large capacitive loads to drive circuits, it is often that timing problems are not discovered until an entire system is constructed. This paper covers the practical aspects of using modern clock drivers in MOS memory systems. Information includes selection of packages and heat sinks, power dissipation, rise and fall time considerations, power supply decoupling, system clock line ringing and crosstalk, input coupling techniques, and example calculations. Applications covered include driving various types shift registers and RAM's (Random Access Memories) using logical control as well as other techniques to assure correct non-overlap of timing waveforms.

Although the information given is generally applicable to any type of driver, monolithic integrated circuit drivers, the DS0025, DS0026 and DS0056 are selected as examples because of their low cost.

The DS0025 was the first monolithic clock driver. It is intended for applications up to one megacycle where low cost is of prime concern. Table I illustrates its performance while Appendix I describes its circuit operation. Its monolithic, rather than hybrid or module construction, was made possible by a new high voltage-gold doped process utilizing a collector sinker to minimize V<sub>CESAT</sub>.

The DS0026 is a high speed, low cost, monolithic clock driver intended for applications above one megacycle. Table II illustrates its performance characteristics while its unique circuit design is presented in Appendix II. The DS0056 is a variation of the DS0026 circuit which allows the system designer to modify the output performance of the circuit. The DS0056 can be connected (using a second power supply) to increase the positive output voltage level and reduce the effect of cross coupling capacitance between the clock lines in the system. Of course the above are just examples of the many different types that are commercially available. Other National Semiconductor MOS interface circuits are listed in Appendix III.

The following section will hopefully allow the design engineer to select and apply the best circuit to his particular application while avoiding common system problems.

# PRACTICAL ASPECTS OF USING MOS CLOCK DRIVERS

#### Package and Heat Sink Selection

Package type should be selected on power handling capability, standard size, ease of handling, availability of sockets, ease or type of heat sinking required, reliability and cost. Power handling capability for various packages is illustrated in Table III. The following guidelines are recommended:

**TABLE I. DS0025 Characteristics** 

PARAMETER	ARAMETER CONDITIONS (V <sup>+</sup> - V <sup>-</sup> ) = 17V		
ton		15	ns
toff	$C_{IN} = 0.0022 \mu F$ , $R_{IN} = 0 \Omega$	30	ns
t <sub>r</sub>	$C_L = 0.0001 \mu F$ , $R0 = 50 \Omega$	25	ns
· t <sub>f</sub>	•	150	ns
Positive Output Voltage Swing	$V_{IN} - V^{-} = 0V, I_{OUT} = -1mA$	V <sup>+</sup> - 0.7	V
Negative Output Voltage Swing	I <sub>IN</sub> = 10mA, I <sub>OUT</sub> = 1mA	V⁻ + 1.0	v
On Supply Current (V <sup>+</sup> )	I <sub>IN</sub> = 10 mA	17	mA

TABLE II, DS0026 Characteristics

PARAMETER	CONDITIONS (V+ - V-) = 17V	VALUE	UNITS
ton		7.5	ns
toff	$C_{IN} = 0.001 \mu F, R_{IN} = 0 \Omega$	7.5	ns
$\dot{\mathbf{t}}_{\mathbf{r}^0}$	$R0 = 50\Omega$ , $C_L = 1000 pF$	25	ns ;
t <sub>f</sub>		25	ns
Positive Output Voltage Swing	V <sub>IN</sub> - V = 0V, I <sub>OUT</sub> = -1mA	V <sup>+</sup> - 0.7	V
Negative Output Voltage Swing	I <sub>IN</sub> = 10mA, I <sub>OUT</sub> = 1mA	V - + 0.5	· V
On Supply Current (V <sup>+</sup> )	I <sub>IN</sub> = 10 mA	28	mA

The TO-5 ("H") package is rated at 750 mW still air (derate at 200°C/W above 25°C) soldered to PC board. This popular cavity package is recommended for small systems. Low cost (about 10 cents) clip-on heat sink increases driving capability by 50%.

The 8-pin ("N") molded mini-DIP is rated at 600 mW still air (derate at 90°C/W above 25°C) soldered to PC board (derate at 1.39W). Constructed with a special copper lead frame; this package is recommended for medium size commercial systems particularly where automatic insertion is used. (Please note for prototype work, that this package is only rated at 600 mW when mounted in a socket and not one watt until it is soldered down.)

To TO-8 ("G") package is rated at 1.5W still air (derate at 100°C/W above 25°C) and 2.3W with clip-on heat sink (Wakefield type 215-1.9 or equivalent-derate at 15 mW/°C). Selected for its power handling capability and moderate cost, this hermetic package will drive very large systems at the lowest cost per bit.

Additional information is given in the section of this data book on Maximum Power Dissipation (page 2).

#### **Power Dissipation Considerations**

The amount of registers that can be driven by a given clock driver is usually limited first by internal power dissipation. There are four factors:

- 1. Package and heat sink selection
- 2. Average dc power, PDC
- 3. Average ac power, PAC
- 4. Numbers of drivers per package, n

From the package heat sink, and maximum ambient temperature one can determine  $P_{MAX}$ , which is the maximum internal power a device can handle and still operate reliably. The total average power dissipated in a driver is the sum of dc power and ac power in each driver times the number of drivers. The total of which must be less than the package power rating.

$$P_{DISS} = n \times (P_{AC} + P_{DC}) \le P_{MAX} \tag{1}$$

Average dc power has three components: input power, power in the "OFF" state (MOS logic "0") and power in the "ON" state (MOS logic "1").

$$P_{DC} = P_{IN} + P_{OFF} + P_{ON}$$
 (2)

For most types of clock drivers, the first two terms are negligible (less than 10 mW) and may be ignored.

Thus:

$$P_{DC} \cong P_{ON} = \frac{(V^+ - V^-)^2}{Reg} \quad x \text{ (DC)}$$

where:

$$V^+ - V^- =$$
 Total voltage across the driver

$$= V^{+} - V^{-}/I_{S(ON)}$$
 (3)

For the DS0025, Req is typically 1 k $\Omega$  while Req is typically 600 $\Omega$  for the DS0026. Graphical solutions for P<sub>DC</sub> appear in *Figure 1*. For example if V<sup>+</sup> = +5V, V<sup>-</sup> = -12V, Req = 500  $\Omega$ , and DC = 25%, then P<sub>DC</sub> = 145 mW. However, if the duty cycle was only 5%, P<sub>DC</sub> = 29 mW. Thus to maximize the number of registers that can be driven by a given clock driver as well as minimizing average system power, the minimum allowable clock pulse width should be used for the particular type of MOS register.

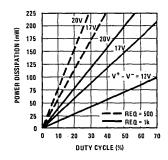


FIGURE 1. P<sub>DC</sub> vs Duty Cycle

In addition to  $P_{DC}$ , the power driving a capacitive load is given approximately by:

$$P_{AC} = (V^+ - V^-)^2 \times f \times C_L$$
 (4)

where:

f = Operating frequency

C<sub>1</sub> = Load capacitance

Graphical solutions for  $P_{AC}$  are illustrated in Figure 2. Thus, any type of clock driver will dissipate internally 290 mW per MHz per thousand pF of load. At 5 MHz, this would be 1.5W for a 1000 pF load. For long shift register applications, the driver with the highest package power rating will drive the largest number of bits.

Combining equations (1), (2), (3) and (4) yields a criterion for the maximum load capacitance which can be driven by a given driver:

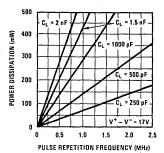


FIGURE 2. PAC vs PRF

$$C_{L} \le \frac{1}{f} \left[ \frac{P_{MAX}}{n (V^{+} - V^{-})^{2}} - \frac{(DC)}{Req} \right]$$
 (5)

As an example, the DS0025CN can dissipate 890 mW at  $T_A = 70^{\circ}$ C when soldered to a printed circuit board. Req is approximately equal to 1k. For  $V^+ = 5V$ ,  $V^- = -12V$ , f = 1 MHz, and dc = 20%,  $C_1$  is:

$$C_L \le \frac{1}{10^6} \left[ \frac{(890 \times 10^{-3})}{(2)(17)^2} - \frac{0.2}{1 \times 10^3} \right]$$

 $C_L \le 1340 \text{ pF (each driver)}$ 

A typical application might involve driving an MM5013 triple 64-bit shift register with the DS0025. Using the conditions above and the clock line capacitance of the MM5013 of 60 pF, a single DS0025 can drive 1340 pF/60 pF, or 00 MM5013's.

In summary, the maximum capacitive load that any clock driver can drive is determined by package type and rating, heat sink technique, maximum system ambient temperature, ac power (which depends on frequency, voltage across the device, and capacitive load) and dc power (which is principally determined by duty cycle).

#### Rise and Fall Time Considerations

In general rise and fall times are determined by (a) clock driver design, (b) reflected effects of heavy external load, and (C) peak transient current available. Details of these are included in Appendixes I and II. Figures AI-3, AI-4, AII-2 and AIII-3 illustrate performance under various operating conditions. Under light loads, performance is determined by internal design of the driver; for moderate loads, by load  $\mathbf{C_L}$  being reflected (usually as  $\mathbf{C_{L/\beta}}$ ) into the driver, and for large loads by peak output current where:

$$\frac{\Delta V}{\Delta T} = \frac{I_{OUT PEAK}}{C_{I}}$$

Logic rise and fall times must be known in order to assure non-overlap of system timing.

Note the definition of rise and fall times in this application note follow the convention that rise time is the transition from logic "0" to logic "1" levels and vice versa for fall times. Since MOS logic is inverted from normal TTL, "rise time" as used in this note is "voltage fall" and "fall time" is "voltage rise."

#### **Power Supply Decoupling**

Although power supply decoupling is a wide spread and accepted practice, the question often arises as to how much and how often. Our own experience indicates that each clock driver should have at least 0.1µF decoupling to ground at the V<sup>+</sup> and V<sup>-</sup> supply leads. Capacitors should be located as close as is physically possible to each driver. Capacitors should be non-inductive ceramic discs. This decoupling is necessary because currents in the order of 0.5 to 1.5 amperes flow during logic transitions.

There is a high current transient (as high as 1.5A) during the output transition from high to low through the  $V^-$  lead. If the external interconnecting wire from the driving circuit to the  $V^-$  lead is electrically long, or has significant dc resistance the current transient will appear as negative feedback and subtract from the switching response. To minimize this effect, short interconnecting wires are necessary and high frequency power supply decoupling capacitors are required if  $V^-$  is different from the ground of the driving circuit.

#### Clock Line Overshoot and Cross Talk

Overshoot: The output waveform of a clock driver can, and often does, overshoot. It is particularly evident on faster drivers. The overshoot is due to the finite inductance of the clock lines. Since most MOS registers require that clock signals not exceed V<sub>SS</sub>, some method must be found in large systems to eliminate overshoot. A straightforward approach is shown in *Figure 3*. In this instance,

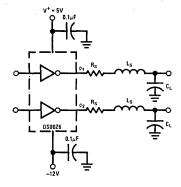


FIGURE 3. Use of Damping Resistor to Eliminate Clock Overshoot

6

a small damping resistor is inserted between the output of the clock driver and the load. The critical value for  ${\sf R}_{\sf S}$  is given by:

$$R_{s} = 2\sqrt{\frac{L_{s}}{C_{1}}} \tag{6}$$

In practice, analytical determination of the value for  $R_S$  is rather difficult. However,  $R_S$  is readily determined empirically, and typical values range in value between 10 and  $50\Omega.$ 

Use of the damping resistor has the added benefit of essentially unloading the clock driver; hence a greater number of loads may often be driven by a given driver. In the limit, however, the maximum value that may be used for  $R_{\rm S}$  will be determined by the maximum allowable rise and fall time needed to assure proper operation of the MOS register. In short:

$$t_{r(MAX)} = t_{f(MAX)} \le 2.2 R_S C_L$$
 (7)

One last word of caution with regard to use of a damping resistor should be mentioned. The power dissipated in  $R_{\rm S}$  can approach  $(V^+-V^-)^2fC_{\rm L}$  and accordingly the resistor wattage rating may be in excess of 1W. There are, obviously, applications where degradation of  $t_{\rm r}$  and  $t_{\rm f}$  by use of damping resistors cannot be tolerated. Figure 4 shows a practical circuit which will limit overshoot to a diode drop. The clamp network should physically be located in the center of the distributed load in order to minimize inductance between the clamp and registers.

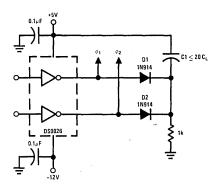


FIGURE 4. Use of High Speed Clamp to Limit Clock Overshoot

Cross Talk: Voltage spikes from  $\phi_1$  may be transmitted to  $\phi_2$  (and vice versa) during the transition of  $\phi_1$  to MOS logic "1." The spike is due to mutual capacitance between clock lines and is, in general, aggravated by long clock lines when numerous registers are being driven. Figure 5 illustrates the problem.

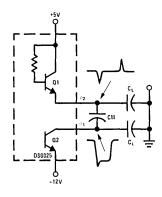


FIGURE 5, Clock Line Cross Talk

The negative going transition of  $\phi_1$  (to MOS logic "1") is capacitively coupled via  $C_M$  to  $\phi_2$ . Obviously, the larger  $C_M$  is, the larger the spike. Prior to  $\phi_1$ 's transition, Q1 is "OFF" since only  $\mu A$  are drawn from the device.

The DS0056 connected as shown in *Figure 6* will minimize the effect of cross talk. The external resistors to the higher power supply pull the base of a Q1 up to a higher level and forward bias the collector base junction of Q1. In this bias condition the output impedance of the DS0056 is very low and will reduce the amplitude of the spikes.

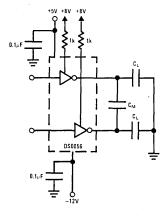


FIGURE 6. Use of DS0056 to Minimize Clock Line Cross Talk

#### Input Capacitive Coupling

Generally, MOS shift registers are powered from +5V and -12V supplies. A level shift from the TTL levels (+5V) to MOS levels (-12V) is therefore required. The level shift could be made utilizing a PNP transistor or zener diode. The disadvantage to do level shifting is the increased power dissipation and propagation delay in the level shifting device. Both the DS0025, DS0026 and DS0056 utilize input capacitors when level shifting from

TTL to negative MOS capacitors. Not only do the capacitors perform the level shift function without inherent delay and power dissipation, but as will be shown later, the capacitors also enhance the performance of these circuits.

#### CONCLUSION

The practical aspects of driving MOS memories with low cost clock drivers has been discussed in detail. When the design guide lines set forth in this paper are followed and reasonable care is taken in circuit layout, the DS0025, DS0026 and DS0056 provide superior performance for most MOS input interface applications.

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- John Vennard, "MOS Clock Drivers," National Semiconductor, MB-9, December 1969.
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#### APPENDIX I

#### **DS0025 Circuit Operation**

The schematic diagram of the DS0025 is shown in Figure Al-1. With the TTL driver in the logic "0" state Q1 is "OFF" and Q2 is "ON" and the output is at approximately one  $V_{BE}$  below the  $V^+$  supply.

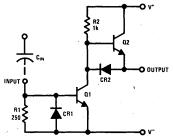


FIGURE AI-1. DS0025 Schematic (One-Half Circuit)

When the output of the TTL driver goes high, current is supplied to the base of Q1, through  $C_{\rm IN}$ , turning it "ON." As the collector of Q1 goes negative, Q2 turns "OFF." Diode CR2 assures turn-on of Q1 prior to Q2's turn-off minimizing current spiking on the V<sup>+</sup> line, as well as providing a low impedance path around Q2's base emitter junction.

The negative voltage transition (to MOS logic "1") will be quite linear since the capacitive load will force Q1 into its linear region until the load is discharged and Q1 saturates. Turn-off begins when the input current decays to zero or the output of the TTL driver goes low. Q1 turns "OFF" and Q2 turns "ON" charging the load to within a  $V_{\rm BE}$  of the  $V^{\dagger}$  supply.

#### Rise Time Considerations

The logic rise time (voltage fall) of the DS0025 is primarily a function of the ac load,  $C_L$ , the available input current and total voltage swing. As shown in *Figure Al-2*,

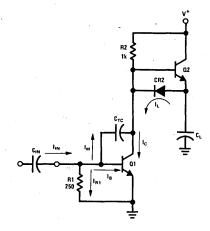


FIGURE A1-2. Rise Time Model for the DS0025

the input current must charge the Miller capacitance of Q1,  $C_{TC}$ , as well as supply sufficient base drive to Q1 to discharge  $C_L$  rapidly. By inspection:

$$I_{IN} = I_M + I_B + I_{R1}$$
 (AI-1)

 $I_{IN} \cong I_M + I_B$ , for  $I_M \gg I_{R1} \& I_B \gg I_{R1}$ 

$$I_{B} = I_{IN} - C_{TC} \frac{\Delta V}{\Delta t}$$
 (AI-2)

If the current through R2 is ignored,

$$I_C = I_B h_{FEQ1} = I_L + I_M$$
 (AI-3)

where:

$$I_L = C_L \frac{\Delta V}{\Delta t}$$

Combining equations AI-1, AI-2, AI-3 yields:

$$\frac{\Delta V}{\Delta t} \left[ C_L + C_{TC} \left( h_{FEQ1} + 1 \right) \right] = h_{FEQ1} I_{IN}$$
 (AI-4)

or

$$t_r \cong \frac{\left[C_L + (h_{FEQ1} + 1)C_{TC}\right] \Delta V}{h_{FEQ1} I_{IN}}$$
 (AI-5)

Equation (AI-5) may be used to predict t, as a function of  $C_L$  and  $\Delta V$ . Values for  $C_{TC}$  and  $h_{FE}$  are 10 pF and 25 respectively. For example, if a DM7440 with peak output current of 50 mA were used to drive a DS0025 loaded with 1000 pF, rise times of:

or 21 ns may be expected for  $V^+ = 5.0V$ ,  $V^- = -12V$ , Figure Al-3 gives rise time for various values of  $C_1$ .

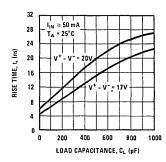


FIGURE AI-3. Rise Time vs CL for the DS0025

#### Fall Time Considerations

The MOS logic fall time (voltage rise) of the DS0025 is dictated by the load,  $C_{\rm L}$ , and the output capacitance of Q1. The fall time equivalent circuit of DS0025 may be approximated with the circuit of Figure AI-4. In actual

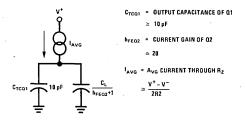


FIGURE AI-4. Fall Time Equivalent Circuit

practice, the base drive to Q2 drops as the output voltage rises toward  $V^+$ . A rounding of the waveform occurs as the output voltage reaches to within a volt of  $V^+$ . The result is that equation (AI-7) predicts conservative values of  $t_f$  for the output voltage at the beginning of the

voltage rise and optimistic values at the end. Figure AI-5 shows  $\mathbf{t}_f$  as function of  $\mathbf{C}_L$  .

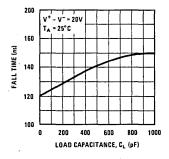


FIGURE AI-5. DS0025 Fall Time vs CL

Assuming  $h_{\text{FE2}}$  is a constant of the total transition:

$$\frac{\Delta V}{\Delta t} = \left(\frac{V^+ - V^-}{2R2}\right)$$
(AI-6)

or

$$t_f \cong 2R2 \left( C_{TCQ1} + \frac{C_L}{h_{EEQ+1}} \right)$$
 (A1-7)

#### DS0025 Input Drive Requirements

Since the DS0025 is generally capacitively coupled at the input, the device is sensitive to current not input voltage. The current required by the input is in the 50–60 mA region. It is therefore a good idea to drive the DS0025 from TTL\_line drivers, such as the DM7440 or DM8830. It is possible to drive the DS0025 from standard 54/74 series gates or flip-flops but toN and tr will be somewhat degraded.

#### Input Capacitor Selection

The DS0025 may be operated in either the logically controlled mode (pulse width out  $\cong$  pulse width in) or  $C_{IN}$  may be used to set the output pulse width. In the latter mode a long pulse is supplied to the DS0025.

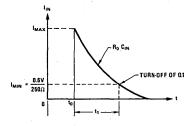


FIGURE AI-6. DS0025 Input Current Waveform

The input current is of the general shape as shown in Figure AI-6.  $I_{MAX}$  is the peak current delivered by the TTL driver into a short circuit (typically 50–60 mA). Q1 will begin to turn-off when  $I_{IN}$  decays below  $V_{BE}/R1$  or about 2.5 mA. In general:

$$I_{IN} = I_{MAX} e^{-t/R0} C_{IN}$$
 (AI-8)

where:

R0 = Output impedance of the TTL driver

CIN = Input coupling capacitor

Substituting  $I_{IN} = I_{MIN} = \frac{V_{BE}}{R1}$  and solving for  $t_1$  yields:

$$t_1 = ROC_{IN} In \frac{I_{MAX}}{I_{MIN}}$$
 (AI-9)

The total pulse width must include rise and fall time considerations. Therefore, the total expression for pulse width becomes:

$$t_{PW} \cong \frac{t_r + t_f}{2} + t_1$$

$$= \frac{t_r + t_f}{2} + ROC_{IN} \ln \frac{I_{MAX}}{I_{MIN}}$$
 (Al-10)

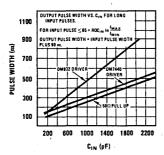


FIGURE AI-7. Output PW Controlled by CIN

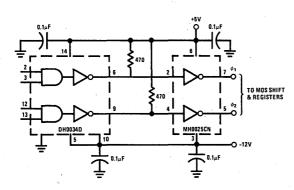


FIGURE AI-9. DC Coupled Clock Driver Using DH0034

The logic "1" output impedance of the DM7440 is approximately 65 $\Omega$  and the peak current (I<sub>MAX</sub>) is about 50 mA. The pulse width for C<sub>IN</sub> = 2,200 pF is:

$$t_{PW} \simeq \frac{25 \text{ ns} + 150 \text{ ns}}{2} + (65\Omega) (2200 \text{ pF}) \text{ In}$$

$$\frac{50 \text{ mA}}{2.5 \text{ mA}} = 517 \text{ ns}$$

A plot of pulse width for various types of drivers is shown in *Figure AI-7*. For applications in which the output pulse width is logically controlled, C<sub>IN</sub> should be chosen 2 to 3 times larger than the maximum pulse width dictated by equation (AI-10).

#### **DC** Coupled Operation

The DS0025 may be direct-coupled in applications when level shifting to a positive value only. For example, the MM1103 RAM typically operates between ground and +20V. The DS0025 is shown in *Figure AI-8* driving the addres or precharge line in the logically controlled mode.

If DC operation to a negative level is desired, a level translator such as the DS7800 or DH0034 may be employed as shown in *Figure AI-9*. Finally, the level shift may be accomplished using PNP transistors are shown in *Figure AI-10*.

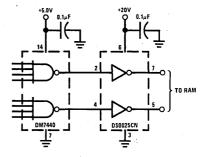


FIGURE AI-8, DC Coupled DS0025 Driving 1103 RAM

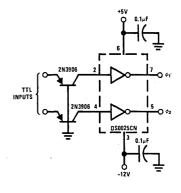


FIGURE AI-10. Transistor Coupled DS0025 Clock Driver

#### APPENDIX II

#### **DS0026 Circuit Operation**

The schematic of the DS0026 is shown in *Figure AII-1*. The device is typically ac coupled on the input and responds to input current as does the DS0025. Internal current gain allows the device to be driven by standard TTL gates and flip-flops.

With the TTL input in the low state Q1, Q2, Q5, Q6 and Q7 are "OFF" allowing Q3 and Q4 to come "ON." R6 assures that the output will pull up to within a  $V_{BE}$  of  $V^+$  volts. When the TTL input starts toward logic "1," current is supplied via  $C_{1N}$  to the bases of Q1 and Q2 turning them "ON." Simultaneously, Q3 and Q4 are snapped "OFF." As the input voltage rises (to about 1.2V), Q5 and Q6 turn-on. Multiple emitter transistor Q5 provides additional base drive to Q1 and Q2 assuring their complete and rapid turn-on. Since Q3 and Q4 were rapidly turned "OFF" minimal power supply current spiking will occur when Q7 comes "ON."

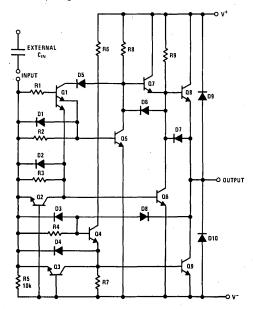


FIGURE AII-1. DS0026 Schematic (One-Half Circuit)

Q6 now provides sufficient base drive to Q7 to turn it "ON." The load capacitance is then rapidly discharged toward V<sup>-</sup>. Diode D4 affords a low impedance path to Q6's collector which provides additional drive to the load through current gain of Q7. Diodes D1 and D2 prevent avalanching Q3's and Q4's base-emitter junction as the collectors of Q1 and Q2 go negative. The output of the DS0026 continues negative stopping about 0.5V more positive than V<sup>-</sup>.

When the TTL input returns to logic "0," the input voltage to the DS0026 goes negative by an amount proportional to the charge on  $C_{\rm IN}$ . Transistors Q8 and Q9 turn-on, pulling stored base charge out of Q7 and Q2 assuring their rapid turn-off. With Q1, Q2, Q6 and Q7 "OFF," Darlington connected Q3 and Q4 turn-on and rapidly charge the load to within a  $V_{\rm BE}$  of  $V^+$ .

#### Rise Time Considerations

Predicting the MOS logic rise time (voltage fall) of the DS0026 is considerably involved, but a reasonable approximation may be made by utilizing equation (AI-5), which reduces to:

$$t_r \cong [C_L + 250 \times 10^{-12}] \Delta V$$
 (AII-1)

For  $C_L$  = 1000 pF,  $V^+$  = 5.0V,  $V^-$  = -12V,  $t_r \cong$  21 ns. Figure AII-2 shows DS0026 rise times vs  $C_L$ .

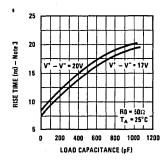


FIGURE All-2. Rise Time vs Load Capacitance

#### **Fall Time Considerations**

The MOS logic fall time of the DS0026 is determined primarily by the capacitance Miller capacitance of Q5 and Q1 and R5. The fall time may be predicted by:

$$t_f \approx (2.2) (R5) \left( C_S + \frac{C_L}{h_{FE}^2} \right)$$

$$\approx (4.4 \times 10^3) \left( C_S + \frac{C_L}{h_{FE}^2} \right)$$
(AII-2)

where:

C<sub>S</sub> = Capacitance to ground seen at the base of Q3

$$h_{FE}^2 = (h_{FEQ3} + 1) (h_{FEQ4} + 1)$$
 $\approx 500$ 

For the values given and  $C_L=1000~pF$ ,  $t_f\cong 17.5~ns$ . Figure AII-3 gives  $t_f$  for various values of  $C_L$ .

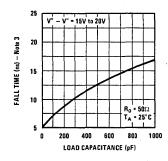


FIGURE All-3. Fall Time vs Load Capacitance

#### **DS0026 Input Drive Requirements**

The DS0026 was designed to be driven by standard 54/74 elements. The device's input characteristics are shown in Figure AII-4. There is breakpoint at V\_{IN}  $\cong$  0.6V which corresponds to turn-on of Q1 and Q2. The input current then rises with a slope of about 600 $\Omega$  (R2 || R3) until a second breakpoint at approximately 1.2V is encountered, corresponding to the turn-on of Q5 and Q6. The slope at this point is about 150 $\Omega$  (R1 || R2 || R3 || R4).

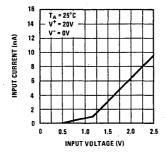


FIGURE All-4. Input Current vs Input Voltage

The current demanded by the input is in the 5–10 mA region. A standard 54/74 gate can source currents in excess of 20 mA into 1.2V. Obviously, the minimum "1" output voltage of 2.5V under these conditions cannot be maintained. This means that a 54/74 element must be dedicated to driving 1/2 of a DS0026. As far as the DS0026 is concerned, the current is the determining turn-on mechanism not the voltage output level of the 54/74 gate.

#### Input Capacitor Selection

A major difference between the DS0025 and DS0026 is that the DS0026 requires that the output pulse width be logically controlled. In short, the input pulse width  $\cong$  output pulse width. Selection of  $C_{\rm IN}$  boils down to choosing a capacitor small enough to assure the capacitor takes on nearly full charge, but large enough so that the input current does not drop below a minimum level to keep the DS0026 "ON." As before:

$$t_1 = ROC_{IN} \ln \frac{I_{MAX}}{I_{MIN}}$$
 (AII-3)

or

$$C_{IN} = \frac{t_1}{R0 \ln \frac{I_{MAX}}{I_{MIN}}}$$
 (AII-4)

In this case R0 equals the sum of the TTL gate output impedance plus the input impedance of the DS0026 (about 150 $\Omega$ ). I<sub>MIN</sub> from *Figure AII-5* is about 1 mA. A standard 54/74 series gate has a high state output impedance of about 150 $\Omega$  in the logic "1" state and an output (short circuit) current of about 20 mA into 1.2V. For an output pulse width of 500 ns,

$$C_{IN} = \frac{500 \times 10^{-9}}{(150\Omega + 150\Omega) \ln \frac{20 \text{ mA}}{1 \text{ mA}}} = 560 \text{ pF}$$

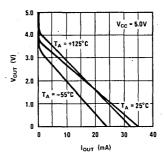


FIGURE AII-5. Logical "1" Output Voltage vs Source Current

In actual practice it's a good idea to use values of about twice those predicted by equation (AII-4) in order to account for manufacturing tolerances in the gate, DS0026 and temperature variations.

A plot of optimum value for  $C_{\rm IN}$  vs desired output pulse width is shown in Figure AII-6.

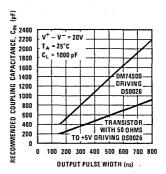


FIGURE All-6. Suggested Input Capacitance vs Output Pulse Width

#### **DC** Coupled Applications

The DS0026 may be applied in direct coupled applications. *Figure AII-7* shows the device driving address or pre-charge lines on an MM1103 RAM.

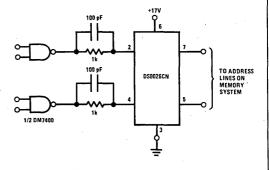


FIGURE All-7. DC Coupled RAM Memory Address or Precharge Driver (Positive Supply Only)

For applications requiring a dc level shift, the circuit of Figure AII-8 or AII-9 are recommended.

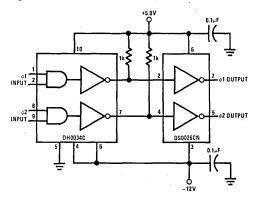


FIGURE AII-8. Transistor Coupled MOS Clock Driver

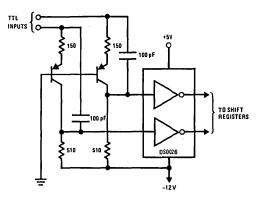


FIGURE AII-9. DC Coupled MOS Clock Driver

#### APPENDIX III

#### **MOS Interface Circuits**

#### **MOS Clock Drivers**

MH0007

	compatible clock driver.
MH0009	Two phase, direct or ac coupled clock driver.
MH0012	10 MHz, single phase direct coupled clock driver.
MH0013	Two phase, ac coupled clock driver.
DS0025C	Low cost, two phase clock driver.
DS0026C	Low cost, two phase, high speed clock driver.
DS3671	Dual bootstrapped MOS driver.
DS3674	Quad MOS clock driver.
DS75361	Dual TTL-to-MOS driver.
DS75365	Quad TTL-to-MOS driver.
MOS RAM Memory	Address and Procharge Drivers

Direct coupled, single phase, TTL

#### MOS RAM Memory Address and Precharge Drivers

DS0025C	Dual address and precharge driver.
DS0026C	Dual high speed address and pre charge driver.

#### TTL to MOS Interface

DH0034	Dual	high	speed	TTL	to	negative
	lovel	conva	rtor			

DS8800 Dual TTL to negative level converter. DS8810/DS8812/ Open collector TTL to positive DS8819 high level MOS converter gates. DS88L12 Active pull-up TTL to positive high level MOS converter gates. Hex TRI-STATE® MOS driver. DS3645/DS3675 Quad TRI-STATE MOS driver I/O DS3647/DS3677 register. TRI-STATE MOS driver multi-DS3648/DS3678 plexer.

#### MOS to TTL Converters and Sense Amps

DS3649/DS3679

DS75107,	Dual sense amp for MM1103 1	k
DS75207	MOS RAM memory.	
Voltage Regulati	ors for MOS Systems	

DS36149/DS36179 Hex TRI-STATE MOS driver.

Hex TRI-STATE MOS driver.

LM309, LM340	Positive regulators.
Series	
LM320 Series	Negative regulators
LM325 Series	Dual +/- regulators





# Section 7 **Dynamic Memory Support**



DEVICE	DEVICE DESCRIPTION						
Family Introduc	etion	•					
AN-302	DP8400 Family of Memory Interface Circuits	7-3					
Dynamic RAM (	Controllers and Drivers						
DP84240	Octal TRI-STATE MOS Drivers	7-15					
DP84244	Octal TRI-STATE MOS Drivers	7-15					
	Single-Chip Controllers Cover All RAMs from 16k to 256k	7-20					
DP8408	Dynamic RAM Controller/Driver	7-26					
DP8409	Multi-Mode Dynamic RAM Controller/Driver	7-43					
DP8419	High Speed Dynamic RAM Controller/Driver	7-64					
App Brief 1	DP8408/09 Application Hints	7-65					
App Brief 9	DP8408/09 Fastest DRAM Access Mode	7-66					
AN-305	Precautions to Take When Driving Memories	7-68					
Error Detection	and Correction						
DP8400	E <sup>2</sup> C <sup>2</sup> Expandable Error Checker and Corrector	7-72					
AN-306	Expanding the Versatility of the DP8400	7-104					
AN-308	DP8400s in 64-Bit Expansion	7-116					
	Error Correction the Hard Way	7-124					
	Simplification of 2-Bit Error Correction	7-127					
	Effortless Error Management	7-134					
Microprocessor	Interface Circuits and Applications						
DP84300	Progammable Refresh Timer	7-139					
DP84312	Dynamic RAM Controller Interface Circuit for the NS16032 CPU	7-144					
DP84322	Dynamic RAM Controller Interface Circuit for the 68000 CPU	7-152					
DP84332	Dynamic RAM Controller Interface Circuit for the 8086 and 8088 CPUs	7-167					
AN-309	Interfacing the DP8408/09 to Various Microprocessors	7-177					
App Brief 2	Memory Systems with ECC Using the DP8400	7-191					

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National Semiconductor Application Note 302 Charles Carinalli Mike Evans March 1983



#### INTRODUCTION

The rapid development in dynamic random access memory (DRAM) chip storage capability, coupled with significant component cost reductions, has allowed designers to build large memory arrays with high performance specifications. However, the development of memory arrays continues to have a common set of problems generated by the complex timing and refresh requirements of DRAMs. These include: how to quickly drive the memories to take advantage of their speed, minimization of board space required by the support circuitry and the need for error detection and correction. Unfortunately, these problems must be addressed with each new system design. Full system solutions will vary greatly, depending on the DRAM array size, memory speed, and the processor.

This application note introduces a complete family of DRAM support circuits that provides a straightforward solution to the above problems while allowing a high degree of flexibility in application with little or no performance penalty. The DP8400 family (Table I) includes DRAM controllers, an expandable error detection/correction circuit, octal address buffers and system control circuits. The LSI blocks are designed with flexible interfaces, making application possible with all existing DRAMs including the recently announced 256Ks. Additionally, interface is easy to all popular microprocessors with memory word widths possible from 8 to 80 bits.

#### TABLE I. DP8400 FAMILY MEMBERS

DP8400	Expandable Error Checker/Corrector
DP8408, DP8409	DRAM Controllers
DP84240, DP84244	DRAM Buffer Drivers
DP84300 Series	Microprocessor Interface Circuits

#### **FULL FUNCTION DRAM CONTROLLER**

The heart of any DRAM array design is the controller function. Previous LSI controllers supplied a minimum function of address multiplexing with an on-board refresh counter. This required external delay line timing and logic to control memory access, additional logic to perform memory refresh, and external drivers to drive the capacitive memory array. The complete solution results in significant access delay in relation to DRAM speeds and skews in output sequencing, as well as a large component count.

A previous LSI solution brought much of this logic on-chip. However, it is limited in application to certain microprocessors and has the disadvantage of all access timing originating from an external clock, whose phase uncertainty generates a delay in actually knowing when an access has started.

The DP8409 multi-mode dynamic RAM controller/driver is the first controller to resolve all of these problems. This Schottky bipolar device provides the flexibility of external access control, along with automatic access timing generation, without the need for an external timing generator clock. In addition, on-board capacitive drivers allow direct drive for over 88 DRAMs. With the simple addition of refresh clocks, the circuit can perform hidden refresh automatically. But possibly one of the DP8409's most important advantages is its upgradability for use with 256K DRAMs.

#### All Control On-Chip

Figure 1 is a block diagram of the DP8409. The ADS input strobes the parallel memory address into the row latches R0-8, the column latches C0-8, and bank select B0 and B1. The nine output drivers may be multiplexed between the row or column input latches, or the 9-bit on-chip refresh counter. One of four RAS outputs is selected during an access cycle by setting the bank select inputs B0 or B1. All four RAS outputs are active during refresh. Either external or automatic control is available on-chip for the CAS output, while an on-chip buffer is provided to minimize skew associated with WE output generation.

All DRAM address and control outputs on the DP8409 can directly drive in excess of 500 pF, or the equivalent of 88 DRAMs (4 banks of 22 DRAMs). All output drivers are closely matched, significantly reducing output skew. Each output stage has symmetrical high and low logic level drive capability, insuring matched rise and fall time characteristics.

#### Flexibility and Upgradability to 256K

The 9 multiplexed address outputs and 9-bit internal refresh counter of the DP8409 not only guarantee its use with all current DRAMs (16K and 64Ks), but also enable direct addressing capability for the forthcoming 256K DRAMs. Careful design of memory boards, using the current 64K DRAMs with the DP8409, will insure direct upgradability to 256K DRAMs. This can be done by simply allowing for board address extension by two bits and designing the ninth address trace (Q8) of the DP8409 to connect to pin 1 of the DRAMs (A8). This is, in general, a nonconnected pin in 64Ks and the ninth address in 256Ks. All that need be done is to remove the 64Ks and replace them with 256Ks, thereby increasing the memory on the same board by a 4 to 1 ratio. The resulting development cost saving can be significant.

Three mode pins (M0, M1 and M2) offer externally selectable modes of operation, a key reason for the DP8409's application flexibility (Table II). The operational modes are divided between external and automatic memory control. Modes 0, 3b, and 4 provide full control of access and refresh for systems with external memory controllers or for special purpose applications. Here all timing can be directly controlled by the external system as shown in Figure 2.

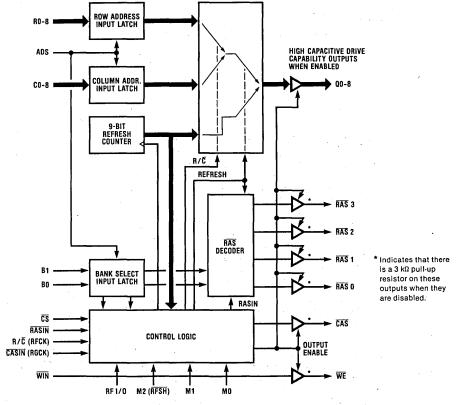


FIGURE 1. DP8409 Block Diagram

**TABLE II. DP8409 MODE SELECT OPTIONS** 

Mode	Mode (RFSH) M1 M0 Mode of Operation		Mode of Operation	Conditions	
0	0	0	0	Externally Controlled Refresh	RF I/O = EOC
1	0	0	1	Auto Refresh—Forced	RF I/O = Refresh Request (RFRQ)
2	0	1	. 0	Internal Auto Burst Refresh	RF I/O = EOC
3a	0	1	1	All RAS Auto Write	RF I/O = EOC
3b	0	1 .	1	Externally Controlled All RAS Access	All RAS Active
4	1.	0	0	Externally Controlled Access	
5	1	0	1	Auto Access, Slow t <sub>RAH</sub> , Hidden Refresh	
6	1	1	0	Auto Access, Fast t <sub>RAH</sub>	
7	1	. 1	1	Set End of Count	

Modes 1, 5 and 6 provide on-chip automatic access sequencing with hidden refresh capability. A graphic example of the automatic access modes of the DP8409 is shown in *Figure 3*. All DRAM access timing and control is generated from one input strobe, RASIN; no external clock is required. On-chip delays insure proper address and control sequencing once the valid parallel address is presented to the fall-through input latches of the DP8409. When the RASIN transitions high-to-low, the decoded RAS output transitions low, strobing the row address into the DRAM array. An on-chip delay automatically generates a guaranteed selectable (mode 5 or 6) row address hold time. At this point, the DP8409 switches the address outputs from the row latch to the column latch. Then another on-chip delay generates a guaranteed column address

set-up time before  $\overline{\text{CAS}}$ , so that the  $\overline{\text{CAS}}$  output automatically strobes the column address into the DRAM array. Read or write cycles are controlled by the system through independent control of the  $\overline{\text{WE}}$  buffer that is provided onchip to minimize delay skewing. The automatic access mode makes the dynamic RAM appear static with respect to access timing. In this mode, only one signal,  $\overline{\text{RASIN}}$ , is needed after valid parallel addresses are presented to the DP8409 to initiate proper access sequencing. Access timing ( $\overline{\text{RASIN}}$  to  $\overline{\text{CAS}}$ ), with full output loading of 88 DRAMs in the auto access mode, is determined by the dash number given on the DP8409 data sheet. All performance characteristics are specified over the full operating temperature and supply ranges.

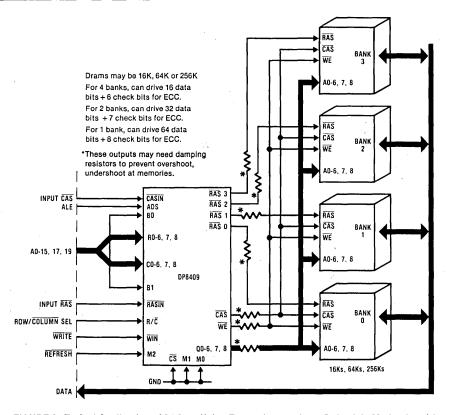


FIGURE 2. Typical Application of DP8409 Using External Control and Refresh in Modes 0 and 4

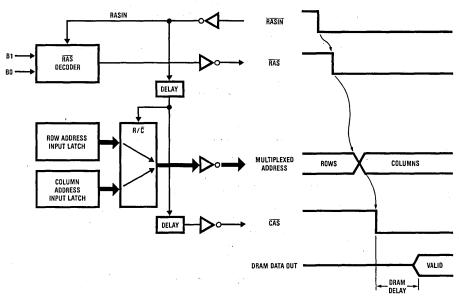


FIGURE 3. This figure demonstrates the automatic accessing capability of the DP8409. Only one strobing edge, RASIN, is required for generation of all DRAM access timing signals. This is accomplished with on-chip delay generators, eliminating the need for external delay lines. No access timing clock is necessary.

#### Refreshing

The DP8409 also provides hidden refresh capability while in one of the automatic access modes (Figure 4). In this mode, it will automatically perform a refresh without the system being interrupted. To do this, the DP8409 requires two clock signals, refresh clock (RFCK) which defines the refresh period (usually 16 µs), and RAS generator clock (RGCK), which is typically the microprocessor clock.

Highest priority is given to hidden refreshing through use of level sensing of RFCK. A refresh cycle begins when RFCK transitions to a high level. If during the time RFCK is high the DP8409 is deselected (CS in the high state) and the processor is accessing another portion of the system such as another memory segment, or ROM, or a peripheral, then a hidden refresh is performed. When a read or write cycle is initiated by the processor, the RASIN input on the DP8409 transitions low. With CS high, this causes the present state of the internal refresh counter to be placed on the address outputs, followed by the four RAS outputs transitioning low, strobing the refresh address into the DRAM array. When the cycle ends, RASIN will terminate, thus forcing the RAS outputs back to their inactive state and ending the hidden refresh. The refresh counter is then incremented and another microprocessor cycle can begin immediately. However, to save power, the DP8409 will allow only one hidden refresh to occur during a given RFCK cycle.

In the event that a hidden refresh does not occur, the DP8409 must force a refresh before the RFCK's next positive-going transition. The system is notified after the

negative-going RFCK transition that a hidden refresh has not occurred, via the refresh request output (RF I/O pin). The system acknowledges the request for a forced refresh by setting M2 (refresh) low on the DP8409 and preventing further access to the DP8409. The DP8409 then uses RGCK to generate an automatic forced refresh. The refresh request pin then returns to the inactive state, and the DP8409 allows the processor to take full system control after the forced refresh has been completed.

#### OCTAL MEMORY DRIVERS

When the memory array becomes large and the 88-DRAM drive capability of the DP8409 becomes insufficient, additional address and control buffers are required. However, like any other element in a DRAM system, selection of the improper driver can have significant impact on system performance.

In the past, this function has been performed using Schottky logic family circuits such as the DM74S240 octal inverter or the DM74S244 octal buffer. The output stages of these devices have good drive capability, but their performance with heavy capacitive loads is not ideal for DRAM arrays. The key disadvantage of these devices is their nonsymmetrical rise and fall time characteristics and their long propagation delays with heavy load capacitance. The former is a result of impedance mismatch in the upper and lower output stages. The latter stems from process capability and circuit design techniques not tallored to the DRAM application. The combined result of all these factors is increased output skew in address and control lines when these devices are used as buffers.

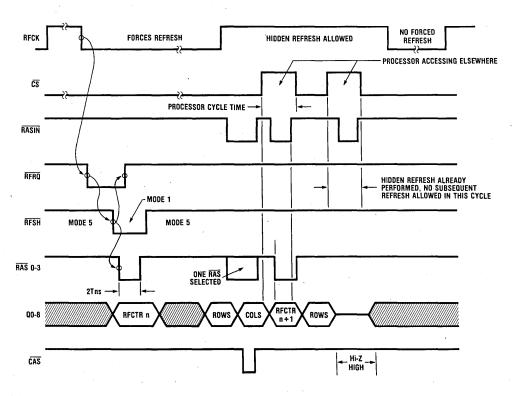


FIGURE 4. Hidden and Forced Refresh Timing of the DP8409

Two new devices are now available for this application. The DP84240 is pin and function compatible with the DM74S240. The DP84244 is likewise compatible with the DM74S244. However, this is where the similarity between the devices ends. Both the DP84240 and the DP84244 have been designed specifically to drive DRAM arrays. *Figure 5* shows a typical application of the DP84244, used in conjunction with the DP8409, to drive a very large memory array.

Figures 6a, 6b show some typical performance curves for these circuits. Note that, at over 500 pF, the propagation delay through these drivers is on the order of 15 ns. This delay includes propagation delay and rise or fall time. Even with this high speed, chip power dissipation

is still maintained at a reasonable level as demonstrated by the graphs shown in *Figures 7a*, 7b of power versus frequency.

The DP84240 and the DP84244 are fabricated on a high performance oxide-isolated Schottky bipolar process. Special circuit techniques have been used to minimize internal delays and skews. Additionally, both rise and fall time characteristics track closely as a function of load capacitance. This has been accomplished through impedance matching of the upper and lower output stages. The result of these characteristics is a substantial reduction of skew in both the address and control lines to the DRAM array.

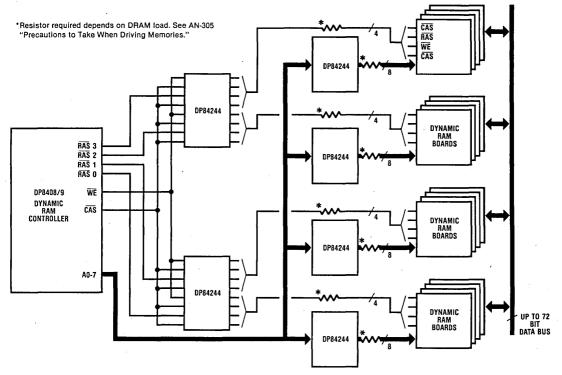


FIGURE 5. The DP84244 Used as a Buffer in a Large Memory Array (greater than 88 DRAMs) Controlled by the DP8409

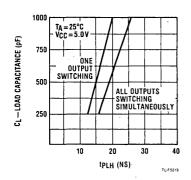


FIGURE 6a. tpLH Measured to 2.7V on Output vs. CL

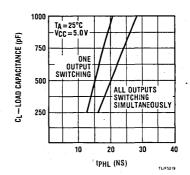


FIGURE 6b. t<sub>PHL</sub> Measured to 0.8V on Output vs. C<sub>L</sub>

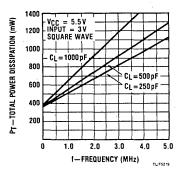


FIGURE 7a. Typical Power Dissipation for DP84240 at V<sub>CC</sub> = 5.5V (All 8 drivers switching simultaneously)

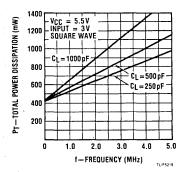


FIGURE 7b. Typical Power Dissipation for DP84244 at V<sub>CC</sub> = 5.5V (All 8 drivers switching simultaneously)

The output stages of the DP84240 and the DP84244, although well matched, are relatively low impedance. Output impedance is under 10Ω. Some DRAM arrays will require the addition of damping resistors in series with the outputs of the drivers. These damping resistors are used to minimize undershoot which may have a harmful effect on the DRAMs if allowed to become large. This undershoot is caused by the high transient currents from the drivers necessary to drive the capacitive loads. These high currents pass through a distributed inductive/capacitive circuit created by the board traces and the DRAM load, causing the undershoot.

The damping resistor has specifically not been placed onchip because its value is dependent on the DRAM array size and board layout. In fact, address lines will quite often require a different resistor value from the DRAM control lines. The resistor must be tuned for a particular board layout since too high a resistor will produce an excessively slow edge and too low a resistor will not remove the undershoot. Values for damping resistors may vary from  $15\Omega$  to  $150\Omega$ , depending on the application. Placing any value of damping resistor on-chip, other than a value less than the minimum, severely restricts the application of these high performance circuits.

Another key advantage of both the DP84240 and the DP84244 is their low input capacitance. Previous address buffer/drivers (such as the DM74S240/244) have high input capacitance. Fast edges at the inputs of these drivers become slower and distorted due to this dynamic input

capacitance. This problem must be factored as an additional delay through these drivers—a delay not shown by the data sheet specifications. Additionally, the problem becomes increasingly severe as multiple driver inputs are used in parallel for bus expansion applications.

Both the DP84240 and the DP84244 are designed to significantly reduce both static and dynamic input capacitance. When these devices are driven with standard logic circuits, no appreciable overhead delay need be added to the basic device delay specifications due to input pulse distortion.

#### **ERROR CORRECTION**

The determination of whether a DRAM system requires error correction must be resolved early in the system design. A positive answer to this question may have farreaching impact on board development time and component cost. It is clear, however, that such a decision cannot be taken lightly.

The type and origin of errors in DRAM systems are many and can result from a number of sources (Table III). Current estimates of soft error rates due to alpha particles in 64K RAMs indicate some hope that these error rates will be similar or possibly better than those found in 16K DRAMS—but the facts are still somewhat unclear. However, it is clear that the introduction in the near future of 256K DRAMs with even smaller memory cells and greater chip densities will place a significant challenge on DRAM chip designers to keep these rates down. It is believed by some that error correction may become mandatory in future DRAM system designs. Currently, the decision to add error correction is not so straightforward. It depends on many factors, not the least of which is the end user's perception of its value to system uptime and reliability.

TABLE III. THE SOURCES AND TYPES OF MEMORY ERRORS

Error Type	Sources	System Action								
Soft	Alpha particles     System noise     Chip patterns     Power glitches	Temporary system error— may be overwritten with a low probability of repetition								
Hard	Stuck memory bit     Memory chip interface     Interface circuit failure	Permanent failure—may act as logic 1 or 0								

Generally, error correction will always be found in highly reliable systems using DRAMs, such as process control equipment, banking terminals, and military systems where high data integrity and minimum downtime are priorities. However, the importance of error correction has grown substantially, to the point that it is now used as a selling feature in the vast majority of large memory-based systems. In fact, some major computer houses have adopted guidelines for use by their designers in the development of DRAM arrays. A somewhat common set has been found if the memory array is on the order of 1/4 million bytes, then word parity should be used. This permits the detection of single bit errors but does not allow error correction. When the total memory approaches 1/2 million bytes, then double bit error detection and single bit error correction should be added.

The decision to add error correction to a system is costly, both in memory overhead and control hardware. Table IV

# TABLE IV. CHECK BIT OVERHEAD FOR MULTIPLE BIT ERROR DETECTION AND SINGLE BIT ERROR CORRECTION

Number of Bits in Memory Data Word	Number of Check Bits Required	Percentage of Excess Memory			
8	5	63%			
16	6	38%			
24	6 (7)	25% (29%)			
32	7	22%			
48	7 (8)	15% (17%)			
64	8	13%			

Note: The number stated assumes the use of the DP8400; the number in parentheses is required by other error correction circuits.

lists the number of additional memory chips required to support single bit error correction and double bit error detection as a function of the memory data word width.

This table also shows the percentage of DRAM overhead required to implement this function. Adding error correction also increases the memory access delay, since the information contained in the overhead chips must be analyzed in each read and generated in each write operation.

#### **DP8400 Expandable Error Correction Chip**

The DP8400 expandable error checker/corrector is shown in block diagram form in *Figure 8*. This circuit offers a high degree of flexibility in applications which range from 8-bit

to 80-bit data words. It is a 16-bit chip that is easily expandable with the simple addition of more DP8400s for each 16-bit word increment.

Figures 9a, 9b and 9c demonstrate its basic operation in the write and read memory access cycles. Figure 9a shows the normal write cycle, where system data is used by the DP8400 to generate parity bits, called check bits. based on certain combinations of the data bits. This combination is defined by the DP8400's matrix shown in Figure 10. Whenever a '1' occurs in any row, the corresponding input data bit at the top of the column helps determine the parity for that check bit labeled at the end of the row. These check bits are written along with the data at the same memory address. Also, during a memory write cycle the DP8400 checks system byte parity. This is parity associated with the data bytes transmitted between the processor and the memory card. This is an optional feature that may prove very valuable in multiple board memory systems.

Sometime later a read will occur at this same memory address. The reading of memory data may be performed in two ways, as shown in *Figures 9b and 9c*. In the read cycle, the DP8400 uses the data read from memory and internally regenerates check bits using the same matrix. These newly generated check bits are then compared (using X-OR gates) with the check bits read from memory to detect errors. The result of this comparison is called a syndrome word. Any differences in the generated versus read check bits will result in at least one syndrome bit true. This indicates an error in either the read data or check bit field or both.

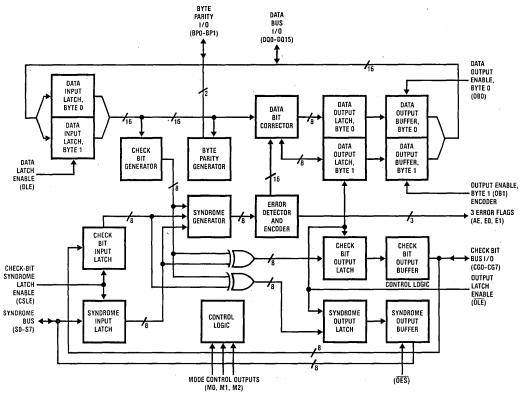


FIGURE 8. DP8400 Simplified Block Diagram

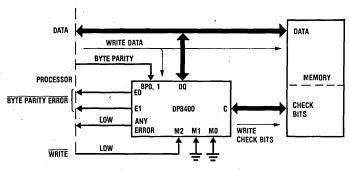


FIGURE 9a. Normal Write Mode with DP8400

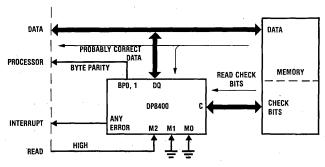


FIGURE 9b. Normal Read Mode Using the Error Monitoring Method with the DP8400

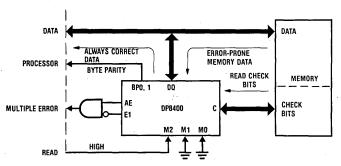


FIGURE 9c. Normal Read Mode Using the Always Correct Method with the DP8400

-		0	1	2	3	4	5	6	7	8	9	1 0	1 1	1 2	1 3	1 4	1 5	}	DQ0-15
		GEN	IERA	TE C	HEC	к віт	s										-		
	0	0	0	-1	1	1	1	-1	1	0	1	1	1	0	1	1	1	0	)
	1	0	0	0	1	0	0	1	0	1	1	0	1	0	1	1	1	1	1
GENERATED	2	1	0	0	1	1	0	0	0	1	0	1	0	1	1	1	1	2*	GENERATED
SYNDROMES	3	0	1	1	0	0	0	0	1	1	1	1	0	1	0	-1	1	3*	CHECK BITS
	4	1	1	0	0	0	1	0	1	1	0 -	0	1	0	1	0	1	4	Billo
	. 5	1	1	1	0	1	1	1	0	1	0	0	0	1	. 1	1	0	5	}
												-							
		4	8	9	7	5	1	3	9	Ε	В	D	3	С	7	F	F	0	
		3	3	2	0	2	3	2	1	3	0	0	1	2	3	2	1	1	
		$\overline{}$																,	

HEXADECIMAL EQUIVALENT OF SYNDROME BITS

FIGURE 10. DP8400 Matrix

<sup>\*</sup> C2, C3 generate odd parity

A key advantage of the DP8400 is that it has three error flags detailing the type of error occurrence. These are generated using the syndrome word in the manner shown in Figure 11. The resulting error type identifications are shown in Table V. The three error flags allow complete error type identification, plus the unique determination of double bit errors, which will be key during the discussion of double bit error correction. Also, on a memory read, the DP8400 generates byte parity bits for transmission to the processor along with the data.

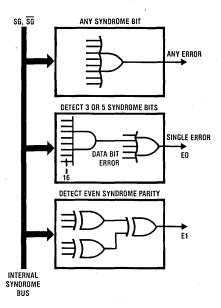


FIGURE 11. The DP8400 Error Encoder Generating 3 Error Flags

#### TABLE V. ERROR FLAGS AFTER NORMAL READ

AE	E1	E0	Error Type	
0	. 0	0	No error	
1	1	0	Single check bit error	
1	1	1	Single data error	
1	. 0	0	Double-bit error	
	All Others		Invalid conditions	

There are two basic memory read methods that may be used with the DP8400. The first is shown in Figure 9b and is called the error monitoring method. Here, the read data is assumed to be correct and the processor immediately acts on the data. If the DP8400 detects an error, the processor is interrupted using the any error flag (AE). Using this method, there is no detection delay in most memory reads since errors seldom occur, but when an error does occur, the processor must be capable of accepting an interrupt and a read cycle extension to obtain the corrected data from the DP8400.

A second approach is called the always correct method, Figure 9c. In this case, the data is always assumed to be in

error and the processor always waits for the DP8400 to analyze whether an error exists. Then the corrected or unchanged data is read from the DP8400. Although this method results in longer memory read time, every memory read will always be of the same delay except when a double error occurs. The selection of which method to use depends on many factors, including the processor, system structure, and performance.

#### **Double Bit Error Correct**

The probability of double bit errors in DRAM systems is relatively low, but as memory array sizes grow, the occurrence of these error types must be considered. Adopting certain practices, such as rewriting a memory location whenever an error is detected, or using "memory scrubbing" techniques, can significantly reduce the probability of a double soft error occurrence. Memory scrubbing is when the system, during low usage, actually accesses memory solely for the purpose of identifying and correcting single soft errors. This is an important technique if there are segments of the memory that are not always being accessed so that soft error occurrences would not be quickly found.

The occurrence of a double error comprising one soft and one hard must now be considered. This type of error has a higher probability than two soft errors. The hard error may be due to a catastrophic chip failure, and a subsequent soft error will create two errors. This can be a source of concern since most error correction chips cannot handle double errors of this type. Therefore, most systems will "crash" when a catastrophic chip failure is coupled with a soft error in the same memory address.

The DP8400 has been designed to handle just such an occurrence. It can correct any double bit error, as long as at least one of the errors is a hard error. The DP8400 does this without the need for extra hardware required for the basic double bit detect/single bit correct system implementation. This method is called the double complement correct technique and is demonstrated in Figure 12 using a 4-bit data word for simplicity. In this example, a single hard error is located in the most significant bit of a particular memory location and a soft error occurs at the next bit. The position of the errors is not important since the errors may be distributed in either the data or check bit field or both. First, the data word and corresponding check bits are written to this memory location. When a later read of this location occurs, step A, two errors are directly reported by the DP8400 error flags. The system detects this, disables memory, and places the DP8400 in the complement write mode. This causes the previously read data and check bits to be complemented in the DP8400 and written back to the same memory address, step B, writing over the previous soft error. Obviously this does not modify the cell where the hard error exists. The system then reads from the same address again, but this time it places the DP8400 in the complement read mode, step C. The DP8400 again complements the memory data and check bits and generates new check bits based on the new data word. At this point, the chip detects a single bit error in the bit position where the soft error occurred, and using the conventional single error correction procedure, returns corrected data to the system, step D.

In the second read, the complement read, the hard error repeats since this bit location again receives a bit which is complemented with respect to itself. But the soft error has

been overwritten and does not repeat. Effectively, the memory has complemented the hard bit error position twice and the soft bit error position only once, while the DP8400 complements both positions twice. Therefore, after the second read, there is only one error left, the soft error. Since this is now a single error it can be directly corrected.

After the complement correct cycle, the memory must be rewritten with the corrected data since the address now contains data that is complemented. Full error reporting is available from the DP8400 after the second read, the complement read, of memory. This is shown in Table VI.

This method is a very effective tool to avoid system crash due to memory chip failure, and can do much to reduce unscheduled field service calls. The only time the system will see a double error that is not directly correctable is when a double soft error occurs. The probability of this is very low if the previously discussed techniques are used. The extra time taken to do an additional read and write of memory is insignificant when the alternative is a system that has a catastrophic failure that requires immediate field service. Using this technique, software may be provided in the system to warn the operator that the system is in a degraded operational mode and that field service should occur shortly. In the meantime, the system will continue to operate properly. The key to the effectiveness of the DP8400 in this application is its three error flags which allow complete error reporting—including a unique double error indication.

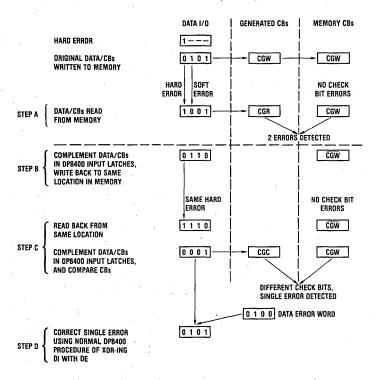


FIGURE 12. Double Error Correct Complement Hard Error Method—
1 Hard Error and 1 Soft Error in Data Bits

#### TABLE VI. DP8400 ERROR FLAGS AFTER A COMPLEMENT READ

AE	E1	E0	Error Type
0	0	0	Two hard errors
1	1	0	One hard error, one soft check bit error
1	1	1	One hard error, one soft data bit error
1	0	0 1	Two soft errors, not corrected

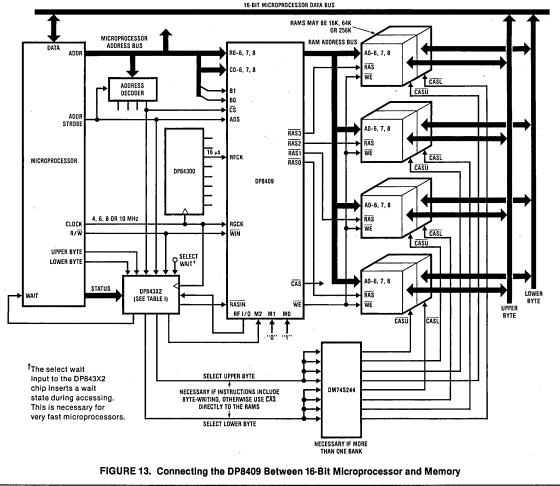
#### MICROPROCESSOR INTERFACE CIRCUITS

The major 8-bit and 16-bit microprocessors have different control signal timing. There are also a number of speed options. The DP8400 family was designed, not for a specific microprocessor, but rather, significant control flexibility has been provided on both the DP8409 and the DP8400 for easy interface to any microprocessor. However, a certain amount of "glue" is necessary to interface to these LSI circuits, usually in the form of a number of MSI/SSI logic circuits. Not only can this be costly in board space utilization, but it is usually the one place where the most design related problems occur in system development.

Figures 13 and 14 show the DP8400 family solution to this problem—the DP84300 series of microprocessor interface circuits. Figure 13 shows how the DP84300 refresh timer and the DP843X2 microprocessor interface circuit connect to the DP8409 and various microprocessors. Figure 14 shows the DP8409 and the DP8400 together in a microprocessor-based memory system using DRAMs, with double bit error detect and single bit error correct capability. In addition, it shows that with the simple addition of some standard data buffers, how the system can implement byte writing to the DRAM array.

This system structure requires the insertion of few or no wait states during a memory access cycle, thus maximizing throughput. The DP84300 circuits have been designed to work with the DP8409 to control refreshing so that system throughput is affected only when absolutely necessary. First, in any refresh clock period of 16  $\mu s$ , hidden refreshing is given maximum opportunity. This can be helped with the optional DP84300 refresh interval generator which offers maximum high-to-low ratioing of RFCK. Second, when a hidden refresh does not occur in a particular RFCK cycle, a forced refresh may still not affect a slow access cycle. The worst-case is when an access is pending during a forced refresh, in which case a three wait state delay is usually the maximum penalty.

Usually two DP84300 type chips would be required to interface between any microprocessor and the DP8400/DP8409 combined system. These chips would handle the read/write control as well as error detection and correction control. Table VII shows the individual DP84300 circuits that would be used in systems with no error correction, thus requiring only the DP8409 DRAM controller.



The DP8400 DRAM interface family provides complete solutions to memory support. This begins with the LSI functions such as the DP8400 expandable error checker/ corrector and the DP8409 DRAM controller/driver. It continues with the DP84240 and the DP84244 high performance buffer/drivers. Finally, it concludes with easy interface to popular microprocessors with the use of the DP84300 series. It is the first family of DRAM support cir-

cuits designed for universal applications with multiple microprocessors.

Data sheets and more detailed application information are available for all the members of the DP8400 family. Contact your local National Semiconductor representative or National Semiconductor directly.

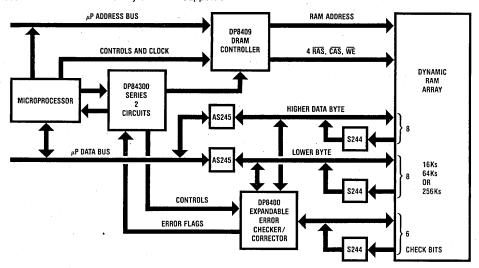


FIGURE 14. Flexible application of the DP8409 and DP8400. This figure shows an application with a 16-bit microprocessor.

## TABLE VII. THE DP84300 SERIES OF INTERFACE CIRCUITS FOR VARIOUS 16-BIT MICROPROCESSORS

16-Bit Microprocessor	System Using Only DP8409
National 16032	DP84312
Motorola 68000	DP84322
Intel 8086/8	DP84332
Zilog 8000	(2) 74S64 (1) 74S04



## **Dynamic Memory Support**

#### DP84240/DP84244 Octal TRI-STATE® MOS Drivers

#### **General Description**

The DP84240 and DP84244 are octal TRI-STATE drivers which are designed for heavy capacitive load applications such as fast data buffers or as memory address drivers. The DP84240 is an inverting driver which is pin-compatible with both the 74S240 and AM2965. The DP84244 is a non-inverting driver which is pin-compatible with the 74S244 and AM2966. These parts are fabricated using an oxide isolation process, for much faster speeds, and are designed for load capacitances of 250pF or greater.

#### **Features**

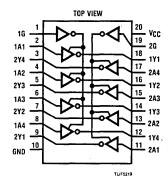
- tpd specified with 250 pF and 500 pF loads
- Output specified from 0.8V to 2.7V
- Designed for symmetric rise and fall times at 500 pF
- Outputs glitch free at power up and power down
- PNP inputs reduce DC loading on bus lines
- Low static and dynamic input capacitance
- Low skew times between edges and pins
- AC parameters specified with all outputs switching simultaneously

TRI-STATE® is a registered trademark of National Semiconductor Corporation

#### **Connection Diagrams**

#### **Truth Tables**

#### DP84240



Inpu G	ıts A	Outputs Y
Н	Х	Z
L	L	н
L	Н	L

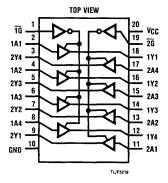
H = High Level

L = Low Level

X = Don't Care

Z = High Impedance

#### DP84244



Inp G	uts A	Outputs Y
Н	х	Z
L	L	L
L	Н	Н

Order Number DP84240J, DP84244J, DP84240N or DP84244N See NS Package J20A or N20A

## Absolute Maximum Ratings (Note 1)

7.0V ·

Logical "1" Input Voltage Logical "0" Input Voltage -1.5V Storage Temperature Range -65°C to +150°C

Maximum Power Dissipation\* at 25°C

Supply Voltage,  $V_{CC}$ 

1667mW Cavity package Molded Package 1832mW Lead Temperature (soldering, 10 seconds) 300°C

**Operating Conditions** 

Max Units V<sub>CC</sub> Supply Voltage 4.5 5.5 T<sub>A</sub> Ambient Temperature 0 +70 °C

## Electrical Characteristics $V_{CC} = 5V \pm 10\%$ , $0 \le T_A \le 70$ °C. See Notes 2 and 3.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IN(1)</sub>	Logical "1" Input Voltage		2.0			٧
V <sub>IN(0)</sub>	Logical "0" Input Voltage				0.8	V
I <sub>IN(1)</sub>	Logical "1' Input Current	V <sub>IN</sub> = 2.7 V		0.1	20	μΑ
	Logical 1 input ourient	V <sub>IN</sub> = 7.0 V			100	μΑ
I <sub>IN(0)</sub>	Logical "0" Input Current	0 ≤ V <sub>IN</sub> ≤ 0.4 V		-50	-200	μΑ
V <sub>CLAMP</sub>	Input Clamp Voltage	I <sub>IN</sub> = -18 mA		-1	-1.2	٧
V <sub>OH</sub>	Logical "1" Output Voltage	$I_{OH} = -100 \mu A$ $I_{OH} = -1 m A$	V <sub>CC</sub> - 1.15 V <sub>CC</sub> - 1.5	4.3 3.9		٧
V <sub>OL</sub>	Logical "0" Output Voltage	I <sub>OL</sub> = 10 μA I <sub>OL</sub> = 12 mA		0.2 0.3	0.4 0.5	٧
I <sub>1D</sub>	Logical "1" Drive Current	V <sub>OUT</sub> = 1.5 V	-75	-250		mA
I <sub>0D</sub>	Logical "0" Drive Current	V <sub>OUT</sub> = 1.5 V	+100	+150		mA
Hi-Z	TRI-STATE Output Current	0.4V ≤ V <sub>OUT</sub> ≤ 2.7V	-100		+100	μА
I <sub>CC</sub>	Supply Current DP84240 DP84244	All Outputs Open All Outputs High All Outputs Low All Outputs Hi-Z All Outputs High		16 74 80 40	50 125 125 75	mA
		All Outputs Low All Outputs Hi-Z		100 115	130 150	

<sup>\*</sup> Derate cavity package 11.1mW/°C above 25°C: derate molded package 14.7mW/°C above 25°C.

Switching Characteristics  $V_{CC} = 5V \pm 10\%$ ,  $0 \le T_A \le 70^{\circ}$ C, all outputs loaded with specified load capacitance and all eight outputs switching simultaneously. (See Note 3.)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
t <sub>PLH</sub>	Propagation Delay from LOW-to-HIGH Output	Fig 1 8 0	$C_L = 250  pF$ $C_L = 500  pF$	9 10	16 20 16 20	27 33 25 31	ns
t <sub>PHL</sub>	Propagation Delay from HIGH-to-LOW Output	Figures 1 & 3	$C_L = 250  pF$ $C_L = 500  pF$	9 12			
t <sub>PLZ</sub>	Output Disable Time from LOW	Figures 2 & 4, S	= 1, C <sub>L</sub> = 50 pF		11	24	ns
t <sub>PHZ</sub>	Output Disable Time from HIGH	Figures 2 & 4, S	= 2, C <sub>L</sub> = 50 pF		12	24	ns
t <sub>PZL</sub>	Output Enable Time to LOW	Figures 2 & 4, S	$= 1, C_L = 500 pF$		30	45	ns
t <sub>PZH</sub>	Output Enable Time to HIGH	Figures 2 & 4, S	$= 2, C_L = 500 pF$		23	35	ns
tskew	Output-to-Output Skew See Note 4.	Figures 1 & 3	C <sub>L</sub> = 500 pF		3		ns

#### Capacitance

 $T_A = 25$ °C, f = 1 MHz,  $V_{CC} = 5V \pm 10$ %. See Note 3.

Parameter	Conditions	Тур	Units
C <sub>IN</sub>	All other inputs tied low	6	pF
C <sub>OUT</sub>	Output in TRI-STATE	20	pF

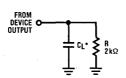
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: All currents into device pins shown as positive; all currents out of device pins shown as negative; all voltages referenced to ground unless otherwise noted. All values shown as max. or min. are on an absolute value basis.

Note 3: Typical characteristics are taken at  $V_{CC} = 5.0 \, \text{V}$  and  $T_A = 25 \, ^{\circ}\text{C}$ .

Note 4: The output-to-output skew is primarily a function of the number of outputs switching and the capacitive loading on those outputs. See Figures 5 and 6 for the switching time variations.

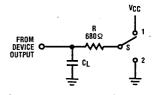
## **Switching Test Circuits**



\*CL INCLUDES PROBE AND JIG CAPACITANCES

TL/F5219

FIGURE 1. Capacitive Load Switching



TL/F5219

FIGURE 2. Three-State Enable/Disable

## **Typical Switching Characteristics**

#### **Voltage Waveforms**

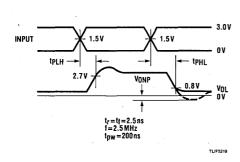


FIGURE 3. Output Drive Levels

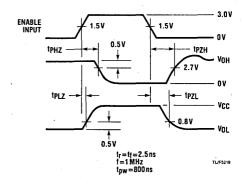


FIGURE 4. Three-State Control Levels

## **Typical Performance Curves**

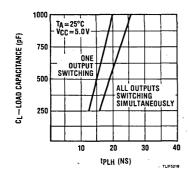


FIGURE 5. t<sub>PLH</sub> Measured to 2.7V on Output vs. C<sub>L</sub>

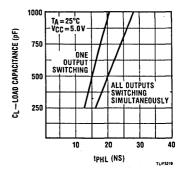


FIGURE 6. t<sub>PHL</sub> Measured to 0.8V on Output vs. C<sub>L</sub>

#### **Typical Performance Curves (Continued)**

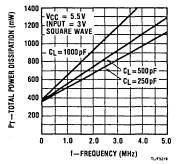


FIGURE 7. Typical Power Dissipation for DP84240 at  $V_{\rm CC} = 5.5 \, {\rm V}$  (All 8 drivers switching simultaneously)

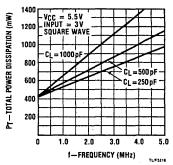
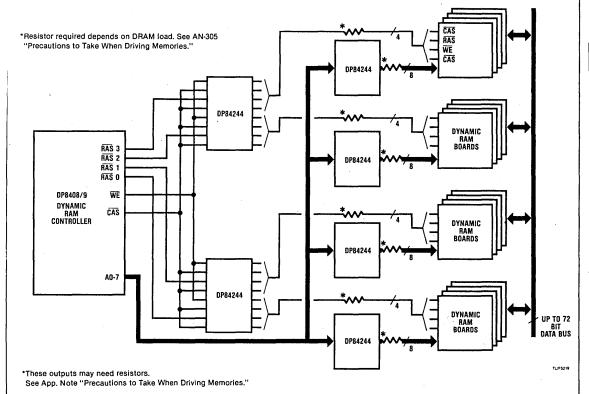


FIGURE 8. Typical Power Dissipation for DP84244 at  $V_{CC} = 5.5V$  (All 8 drivers switching simultaneously)

## **Typical Application**



DP84244 used as a buffer in a large memory array (greater than 88 dynamic RAMs)

A family of single-chip dynamic RAM controllers provides the access-timing and refreshing capability for any chip made, or projected.

# Single-chip controllers cover all RAMs from 16-k to 256-k

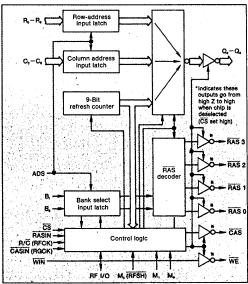
While the high performance and low cost of MOS dynamic RAMs make them the most widely used digital semiconductor devices, operating them is more difficult than most other memory chips. Demands are growing for both the automatic sequencing of RAM-access timing and the automatic control of refreshing. National Semiconductor's response is the DP8400 family of memory-interface circuits. The first two members, the DP8408 and the DP8409, are powerful single-chip dynamic-RAM controllers housed in 48-pin dual-in-line packages and, more important, designed to drive the entire range of dynamic RAMs.

The DP8408's eight address outputs drive all current 16-k and 64-k dynamic RAMs. The DP8409, with nine address outputs, not only handles the same RAMs as the 8408, but can control the coming generation of 256-k memory chips. Both devices are pin-compatible, which means a system designed with the DP8408 to control 64-k chips can be directly upgraded to the DP8409 when 256-k RAMs appear on the market. Another benefit for designers is alternate-sourcing—the first DP8400 devices are available from Monolithic Memories (Sunnyvale, CA).

The DP8408, a subset of the DP8409, fits into applications that do not require automatic refreshing. But it does have automatic access modes. The DP8409 is designed for any type of dynamic RAM system, from small microprocessor-based systems to large memory boards. An automatic-accessing mode makes it desirable in mainframes, since it reduces skew time to that of just one chip, while offering tracking of the RAM input controls. This faster accessing permits the use of slower RAMs. With 64-k RAMs, for example, the cost

savings between 200-ns and 150-ns devices is significant when large quantities are involved.

Microprocessor users will prefer the DP8409 to other controllers because a single chip performs all the basic automatic access sequencing and automatic refreshing control. (If desired, external refreshing can be used with either controller.) Fast automatic accessing eliminates the need for the wait states that are normally required in faster microprocessors. Automatic refreshing eliminates complicated refresh-arbitration control circuitry while offering a



With a 9-bit output bus suitable for interfacing with the largest dynamic RAMs (256 k), National Semiconductor's DP8409 RAM controller drives every RAM available. Features include automatic accessing, automatic refreshing, and high-impedance outputs when not selected. An 8-bit version, the DP8408, operates with RAMs up to 64 kbits, and is used in applications that do not require automatic refreshing.

Mike Evans, Applications Manager, Logic Group Charles Carlnalli, Design Manager, Interface Circuits

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hidden refresh feature to increase the system throughput. The DP8409 offers full control, including byte writing, of the 68000, 8086, and Z8000 microprocessors, and National Semiconductor's new 16032 16-bit microprocessor.

Controlling a dynamic RAM is no simple task (see "Dynamic RAM Operation—from RAS to CAS"). Three timing delays are required for an access, and refreshing must be performed continually. With the arrival of powerful 16-bit processors and their large, direct memories, a single-chip controller becomes necessary for efficient system design. Propagation timing delays through the controller must be in the tens of nanoseconds to minimize total access time. Moreover, to eliminate the propagation delays caused by additional memory drivers, a controller should be capable of directly driving a large number of RAMs. The controller must also reduce component cost and conserve PC-board area.

To fulfill these requirements, the DP8408 and 8409 are fabricated in bipolar technology rather than MOS. LSI capability exists in bipolar technology, and bipolar dynamic-RAM controllers are already available. Two such controllers, Intel's 8202 and AMD's 2964 (AMZ8164), represented early attempts to bring timing delays under system control.

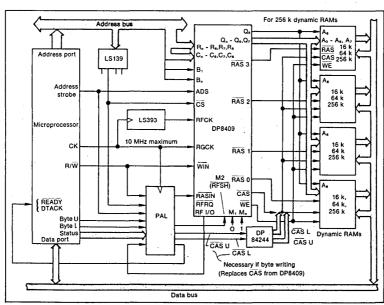
In the Intel device, the clock is independent of the

access-request signal, causing excessive synchronizing delays before the appearance of the output signals. This leads to long system access times, and for most 16-bit microprocessors requires the insertion of wait states. The AMD controller is an address multiplexer with an on-board refresh counter and bank selection for up to four banks of RAMs. While this device drives a small number of RAMs, AMD offers octal memory drivers that can be placed between the 2964 and the RAMs. Delays become progressively longer as timing signals proceed through the delay timer, the 2964, and the additional drivers. And external components are needed to initiate timing delays. Quite simply, the DP8408 and DP8409 go well beyond the access-time and functional capabilities of the 8202 and 2964.

#### On board the RAM controllers

A functional block diagram of the DP8409 is shown in Fig. 1. The DP8408 is similar, except for its 8-bit-wide multiplexed address-bus and the fact that its R/C and CASIN inputs do not provide dual functions as RFCK and RGCK inputs, as they do in the 8409.

The multiplexed address outputs of both controllers can be selected from the row or column input latches, or from the refresh counter. A high level on input signal ADS enables input row-addresses,  $R_0$ 



2. The Interface of the DP8409 RAM controller to a 16-bit microprocessor looks ahead to the day when 256-kbit dynamic RAMs are available. By designing-in the controller now, no modifications to printed-circuit boards will be necessary when 256-k devices are developed. Simply exchanging controller chips will allow the memory-control capability of a microprocessor to increase by four times.

through  $R_8$ , input column-addresses  $C_0$  through  $C_8$ , and bank-select inputs  $B_0$  and  $B_1$  into their respective input latches. ADS also latches these signals on its low-going edge. In a normal RAM access,  $B_0$  and  $B_1$  are decoded to determine which bank is selected. By enabling one of the four RAS outputs (when  $\overline{\rm RASIN}$  goes low), the contents of the row-address latch are strobed into the selected RAMs.

Now the control logic causes the row addresses to be replaced with the column addresses, and CAS goes low as determined by the control logic. This causes the contents of the column-address latch to be strobed into the selected RAMs.

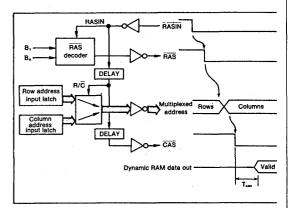
On a write cycle, WE must be low as CAS goes low; on a read cycle, WE must be high. For a read-modify-write cycle, WE must go low some time after CAS—this is specified in RAM data sheets. To simplify control, WE follows WIN unconditionally 20 ns later, typically. Three mode pins—Mo, M1, and M2 (M2 is refresh mode)—offer externally selected operating modes. For example, mode 5—automatic access—identified by code 101, can be changed to mode 1—forced refresh—identified by code 100, when M2 is driven low. These modes include automatic and external control of accesses, and various refreshing modes.

Input pin  $\overline{\text{CS}}$  selects or deselects the controller to allow for multiaddressing of memory. For accesses,  $\overline{\text{CS}}$  is normally low, but to access a second DP8409 sharing the same memory,  $\overline{\text{CS}}$  of the first 8409 must go High. This puts the three-state address outputs in a high-impedance high-state through an external 5-k\(\omega\) pull-up resistor, and sets the control signals to a high impedance to prevent them from drifting low; a low level can result in a false access. Switching between chips takes about 30 ns, providing fast multiaddressing. Refreshing must be performed using only one chip. As  $\overline{\text{CS}}$  goes high in mode 5, deselection is overridden and, provided RFCK is already high, hidden refreshing can occur.

Input/output pin RF I/O can be used to clear the refresh counter when it has been set low by an external open-collector gate. It also sends out an end-of-count signal—a low level—when the refresh counter has filled (counts are selectable to 127, 255, or 511). This is a useful feature for burst refreshing. In the automatic-refresh mode, RF I/O becomes the signal Refresh Request.

#### No problems with capacitive loads

One important asset of the DP8408 and 8409 is their ability to drive high-capacitance loads. RAM inputs are generally specified as having a maximum input capacitance of 10 pF/pin, but in large RAM systems, the worst-case input capacitance is usually on the order of 2.5 pF per input. However, one or two devices



 The DP8408/8409's automatic-accessing capability uses on-chip delay paths to provide faster access while saving on external delay-timing circuitry. On-chip Schottky inverters track extremely well with temperature and voltage, keeping access-times stable.

in a system can go up to 10 pF, especially at high temperature. On the other hand, RAM input currents carry specifications of around 10 µA maximum, but actual input currents seldom exceed 3 µA per input in large systems. Of the two parameters—capacitance and input current—high capacitance always causes more system problems.

In addition to a RAM's input capacitance, designers must consider the capacitance of the PC-board traces. The value of capacitance depends on trace length, nearness to other traces, board thickness, etc. Generally, this amounts to about 3.2 pF per input, giving a total worst-case input capacitance of 5.7 pF/input.

The output stages of the DP8408/8409 can drive up to 88 RAMs, or 500 pF of capacitive loading. Looking at it another way, the controllers can drive four banks each of 16-data bits plus 6 associated check bits for error correction; two banks of 32 data bits with 7 check bits; one bank of 64 data bits with 8 check bits; or any smaller combination. Output rise and fall times are proportional to the capacitive loading, and more than 500 pF increases transition time. Similarly, less than 500 pF decreases propagation delays.

The output-driver stages of the DP8409/8409 are matched. Each stage has symmetrical high and low drive capability, which require that the high and low on-resistances be the same. High output currents are needed to quickly charge or discharge the effective RAM load capacitance on each output. In most applications, a series damping resistor is required between each output and the RAM to minimize undershoot. Undershoot occurs at RAM inputs having both inductive board traces and high capacitive loads on high-to-low transitions.

The value of the series damping resistor depends heavily on the board layout. Address lines usually use a value different from control lines, but both are functions of layout and input loading. The resistor is almost tuned to a specific board since too high a value yields an excessively slow edge, while too low a value does not remove the undershoot. In any case, damping-resistor values vary from 15 to 100  $\Omega.$ 

#### Control over all RAMs

The DP8408 and 8409 are designed to control all multiplexed-address dynamic RAMs. The DP8408, with eight multiplexed address outputs and an 8-bit refresh counter, controls 16-k dynamic RAMs (+5 V or three-power-supply types) and both configurations of 64-k RAMs (128 rows by 512 columns or 256 rows by 256 columns). Memory users can specify either of the two 64-k RAM configurations provided the refresh counter on the DP8408 is used. This replaces on-the-RAM refresh counters offered by some RAM manufacturers.

The DP8409's nine address pins and 9-bit refresh counter allow it to control 16-k, 64-k, and 256-k RAMs. Designers can take advantage of the 8409's 256-k capability by building current memory boards using the device. No modifications will be needed when the 256-k RAMs are available. By simply providing for two new input address lines and connecting  $Q_8$  (the ninth multiplexed address output) to  $A_8$  (pin 1) of the RAMs, the memory size can be increased instantly by a factor of four. Figure 2 shows how the connections are made.

Automatic accessing capability is provided by the 8408 and 8409 using on-chip delay paths to generate the correct timing sequence (Fig. 3). These delays are initiated from only one input signal, RASIN. This generates all the access-sequencing required by most RAMs. Automatic accessing operates in the following manner: First, RASIN is used to generate the selected RAS output as decoded from bank-select signals B<sub>1</sub> and B<sub>0</sub>. RASIN is also fed to the first series of Schottky inverters to produce the necessary delay before rows can be switched to columns. This guarantees exceeding the row-address hold time (t<sub>RAH</sub>) of most RAMs. For 64-k RAMs, t<sub>RAH</sub> varies from 20 to 25 ns, so the minimum specification for the 8408 and 8409, 30 ns, is on the safe side. If the address outputs are driving 500-pF loads, switching from row addresses to valid column addresses takes 10 ns. The second series of inverters set CAS low 12 ns (typically) after the columns are valid.

The inverters track with temperature and  $V_{\rm CC}$ , as do the output driver stages. Tracking of the output paths holds over the specified temperature and  $V_{\rm CC}$  ranges. Since Schottky-logic parameters do not vary significantly with temperature or  $V_{\rm CC}$ , the absolute

times are not affected by more than 25% over the 0 to 70°C range. At the end of an access-cycle, RASIN goes high and the sequence repeats at a higher speed to terminate the cycle.

An automatic-access mode offers two important advantages: First, there is no need for external timing delay circuitry—this saves cost, memoryboard area, and the timing skews that external circuitry introduces. Second, this sequence is much faster than a clocked sequencing approach—that is, the delay from RASIN input to CAS output is much shorter. Benefits include a faster system access time, the possibility of eliminating a wait state in a microprocessor memory-access cycle, or the ability to choose slower RAMs (a lower-cost solution) without affecting access time. And since both chips need no external memory drivers, the timing skews are confined to just one chip.

If automatic timing is not desired, another mode allows all timing to be under the control of the relevant external control signals.  $\overline{\text{RASIN}}$  initiates the selected  $\overline{\text{RAS}}$  output,  $R/\overline{C}$  selects either the row or column address, and  $\overline{\text{CASIN}}$  controls  $\overline{\text{CAS}}$ .

#### Refreshing comes in many forms

The DP8408 performs refresh operations only under external control. The microprocessor system decides when a refresh is needed by setting  $M_2$  (REFRESH) low to place the refresh counter contents on the address outputs. Then the system sets  $\overline{\text{RASIN}}$  low to allow all four RAS outputs to low-stroke the refresh address into the rows of all four banks of RAMs.  $\overline{\text{CAS}}$  is inhibited, preventing a false write, and the RAM data outputs remain in a high-impedance state

A refresh cycle ends when  $\overline{\text{RASIN}}$  goes high and the refresh counter increments, ready for the next refresh cycle. Most RAMs require that all 128 rows be refreshed in 2 ms, or 256 rows in 4 ms. This can be accomplished by either guaranteeing a refresh on one row every 16  $\mu\text{s}$ , or performing a burst refresh of 128 rows at the start of each 2-ms period, until RF I/O indicates end-of-count. Most system designers prefer one refresh every 16  $\mu\text{s}$ . But this can involve inhibiting normal memory accessing, and requires refresh arbitration.

The end-of-count indication on RF 1/O can be set under external system control to either 127 or 255 for burst-refresh applications. Actually, the internal address counter still counts to its maximum value, independent of the end-of-count value—the RF 1/O value is a result of counter decode and does not reset the counter. This simplifies the RAM interface since the higher-order address bit-count is ignored by RAMs with 128 rows.

In addition to providing the external-control

refresh mode of the 8408, the 8409 performs hidden refreshing in one of the automatic-access modes. To attain maximum throughput, it is obviously advantageous to perform refreshes without interrupting the system. The DP8409 can do this by monitoring the  $\overline{\text{CS}}$  input to see if it is high. If  $\overline{\text{CS}}$  is high, the RAMs are not being accessed. If  $\overline{\text{CS}}$  is high for one cycle, the 8409 performs a hidden refresh during this cycle, and stops in time for the system to start another access. But if a hidden refresh does not occur

in a specific 16-µs time slot, a refresh must be forced, possibly by stopping the system.

To perform auto-refreshing, the DP8409 must receive two clock signals: the 16- $\mu$ s refresh-period clock, RFCK, and RGCK, the RAS-generator clock; RGCK can be the microprocessor clock. To keep the number of pins at 48, RFCK and RGCK share pins with other signals. In the automatic-access mode (mode 5), neither R/ $\overline{\text{C}}$  nor  $\overline{\text{CASIN}}$  are used, so these duplicate as RFCK and RGCK in modes 1 and 5. To stop the

#### Dynamic RAM operation—from RAS to CAS

The operation of a dynamic RAM (see figure) is, in a word, complex: Not only do its multiplexed address inputs require delayed timing signals, but it must be refreshed continually.

During an access to a RAM, the first step requires that a row address be presented to the multiplexed address inputs. As the rowaddress signal ( $\overline{RAS}$ ) goes low, the address is latched into the row latch, and decoded to the memory array. There, the outputs from the selected row are presented to the sense amplifiers. Row addresses must be held on the address inputs for a predetermined time— $t_{RAIL}$  or row-address hold-time—after  $\overline{RAS}$  switches low.

At this time, the row address can be replaced by a column-address. When a column address is valid, the column-address strobe (CAS) goes low to latch the address into the column latch. Column-addresses are decoded to allow a selected sense amplifier to send data to the output data-latch (during a read cycle). In a write cycle, with the Write Enable signal (WE) already low, a low-going CAS

signal causes the selected cell to be set to the value at the data input.

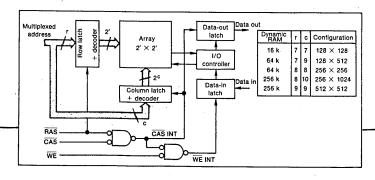
The RAM block diagram shows the chip's operation, including the internal gating of the control signals. One key feature is that RAS internally controls CAS. Thus. if RAS is already low when CAS goes low, a normal read or write cycle follows, and the chip consumes its full operating current. On the other hand, if CAS goes low while RAS is high, CAS INT is inhibited along with RAS, and the RAM consumes only the current required for standby. In this case, the chip is deactivated. Similarly, WE INT is controlled by both RAS and CAS

This simplifies bank selection by using different RAS outputs to select the banks. CAS and WE can be common to all the RAM-banks, along with the multiplexed addressing. For example, in a fourbank system, only one RAS goes low in any access-cycle. This activates all the RAMs in a selected bank, but does not activate RAMs in the other three banks. These latter RAMs remain in the standby mode. The common data bus accesses only the selected

bank, whether reading or writing.

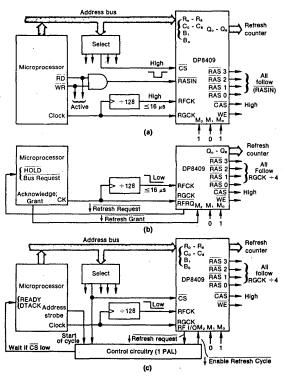
Besides a complex sequencing arrangement, dynamic RAMs must be refreshed to prevent the capacitor in each cell from losing its charge, which represents information. If any row is not accessed for too long a period of time—the refresh period—capacitors will discharge, causing the voltage to drop below the sense-amplifier threshold. Then, when the row is finally accessed, its outputs will appear as all zeros or all ones, depending on which side of the sense amplifier is accessed.

Most RAMs have 2-ms minimum refresh times, but 64-k dynamic RAMs are typically much higher. When accessing a row for refresh, RAS is needed for a strobe, but CAS is not necessary. The simplest approach to refreshing is to access a refresh counter that increments at the end of each refresh RAS. For some RAMs, 128 rows must be refreshed in 2 ms. while others require refreshing 256 rows in 4 ms. With distributed refreshing, one row must be refreshed every 16 µs for proper operation.



system, the DP8409 gives preference to hidden refreshing using RFCK as a level reference. The 16-\$\mu \text{s}\text{ cycle}\text{ commences as RFCK goes high; if CS goes high while RFCK is high, the refresh counter is enabled on the address outputs, overriding the internal three-state signals (Fig. 4a). All four RAS outputs follow RASIN, so to perform a refresh, RASIN must be set low. In smaller systems, RASIN is set low every time a microprocessor performs a read or write cycle. Each time the processor accesses something other than RAM—a peripheral or ROM or another memory segment—a hidden refresh is performed.

The DP8409 detects that  $\overline{\text{CS}}$  is high when the processor accesses another section of the system and places the present state of the refresh counter outputs on the multiplexed address bus to memory. When the Read or Write output of the microprocessor is activated, RASIN follows. This causes all four RAS outputs to low-strobe the refresh



4. Automatic refreshing can be performed in three different ways with the DP8409 controller. A hidden refresh (a) occurs while the microprocessor is reading or writing elsewhere in the system. Although undesirable, forced refreshing (b) can be performed by stopping the microprocessor. A better technique for forced refreshing (c) is to insert wait states into the processor timing cycle.

address into the RAMs. When the cycle ends,  $\overline{RASIN}$  ends, forcing the four  $\overline{RAS}$  outputs back to their inactive states. This ends the hidden refresh.

At this time, the refresh counter increments, and another microprocessor cycle can begin immediately. This cycle can be a memory access; therefore, the previous refresh cycle has been completely hidden from the microprocessor. The DP8409 allows only one such hidden refresh cycle to occur within a clock cycle of RFCK to minimize power dissipation.

If a hidden refresh does not occur, the DP8409 must force a refresh before RFCK begins a new cycle on a low-to-high transition. Therefore, as RFCK goes low (and a hidden refresh has not occurred), RF I/O (Refresh Request) goes low requesting that a refresh be performed. When the system acknowledges the request, it sets M<sub>2</sub> (refresh) low, and prevents further accesses to the DP8409. The 8409 then sends out the refresh-counter contents and interrogates RGCK—in most applications, RGCK is 100 to 150 ns. The 8409 waits one full cycle of RGCK before setting all four RAS outputs low. This guarantees that the minimum RAS precharge time of the RAMs is exceeded. Then RF I/O goes high, allowing the system to recognize that holding is about to end. Most microprocessors allow enough time so that as refresh finishes, they are almost ready to begin again. The RAS outputs remain low for the next two clock periods to exceed the minimum t<sub>RAS</sub> time for refreshing-200 ns is about the right time. When all RAS outputs go high, the refresh counter increments.

A minimum component-count solution to forced refreshing is to connect RF-I/O to the Hold or Bus-Request input of a microprocessor, and the Hold Acknowledge or Bus Grant output to M2 (Fig. 4b). For some microprocessors, it may be preferable to continue operation without going into hold, and with additional circuitry, the approach can be easily implemented as shown in Fig. 4c. Using this technique of forced refreshing, the control circuit monitors the refresh-request output. When this output switches low, the control circuit waits for a new microprocessor cycle to begin. If the next cycle is for the segment of memory controlled by the DP8409, cs and the control circuitry will be set low. The control circuitry issues a Wait signal to the microprocessor, which is removed when refreshing has ended. If  $\overline{\text{CS}}$  is set high, the refresh cycle begins and ends without affecting other system cycles. In effect, this is still a hidden refresh.

## National Semiconductor

## **Dynamic Memory Support**

## **DP8408 Dynamic RAM Controller/Driver**

#### **General Description**

Dynamic memory system designs, which formerly required several support chips to drive the memory array, can now be implemented with a single IC...the DP8408 Dynamic RAM Controller/Driver. The DP8408 is capable of driving all 16k and 64k Dynamic RAMs (DRAMs). Since the DP8408 is a one-chip solution (including capacitive-load drivers), it minimizes propagation delay skews, the major performance disadvantage of multiple-chip memory drive and control.

The DP8408's 6 modes of operation offer a wide selection of DRAM control capabilities. Memory access may be controlled externally or on-chip automatically; an on-chip refresh counter makes refreshing less complicated.

The DP8408 is a 48-pin DRAM Controller/Driver with 8 multiplexed address outputs and control signals. It consists of two 8-bit address latches, an 8-bit refresh counter, and control logic. All output drivers are capable of driving 500 pF loads with propagation delays of 25 ns. The DP8408 timing parameters are specified driving the typical load capacitance of 88 DRAMs, including trace capacitance.

The DP8408 has 3 mode-control pins: M2, M1, and M0, where M2 is in general REFRESH. These 3 pins select 6 modes of operation. Inputs B1 and B0 in the memory access modes (M2 = 1), are select inputs which select one of four RAS outputs. During normal access, the 8 address outputs can be selected from the Row Address Latch or the Column Address Latch. During refresh, the 8-bit on-chip refresh counter is enabled onto the address bus and in this mode all RAS outputs are selected, while CAS is inhibited.

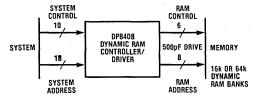
The DP8408 can drive up to 4 banks of DRAMs, with each bank comprised of 16k's, or 64k's. Control signal outputs  $\overline{RAS}$ ,  $\overline{CAS}$ , and  $\overline{WE}$  are provided with the same drive capability. Each  $\overline{RAS}$  output drives one bank of DRAMs so that the four  $\overline{RAS}$  outputs are used to select the banks, while  $\overline{CAS}$ ,  $\overline{WE}$ , and the multiplexed addresses can be connected to all of the banks of DRAMs. This leaves the non-selected banks in the standby mode (less than one tenth of the operating power) with the data outputs in TRI-STATE®. Only the bank with its associated  $\overline{RAS}$  low will be written to or read from.

#### **Operational Features**

- All DRAM drive functions on one chip minimizes skew on outputs, maximizes AC performance
- On-chip capacitive-load drives (specified to drive up to 88 DRAMs)
- Drives directly all 16k and 64k DRAMs
- Capable of addressing 64k and 256k words
- Propagation delays of 25ns typical at 500pF load
- CAS goes low automatically after column addresses are valid if desired
- Auto Access mode provides RAS, Row to Column, select, then CAS automatically and fast
- WE follows WIN unconditionally—offering READ, WRITE or READ-MODIFY-WRITE cycles
- On-chip 8-bit refresh counter with selectable End-of-Count (127 or 255)
- End-of-Count indicated by RF I/O pin going low at 127 or 255
- Low input on RF I/O resets 8-bit refresh counter
- CAS inhibited during refresh cycle
- Fall-through latches on address inputs controlled by ADS
- TRI-STATE outputs allow multi-controller addressing of memory
- Control output signals go high-impedance logic "1" when disabled for memory sharing
- Power-up: counter reset, control signals high, address outputs TRI-STATE, and End-of-Count set to 127

#### **Mode Features**

- 6 modes of operation: 3 access, 1 refresh, and 2 set-up
- 2 externally controlled modes: 1 access (Mode 4) and 1 refresh (Modes 0, 1, 2)
- 2 auto-access modes RAS → R/C → CAS automatic, with t<sub>RAH</sub> = 20 or 30 ns minimum (Modes 5, 6)
- Externally controlled All-RAS Access modes for memory initialization (Mode 3)
- End-of-Count value of Refresh Counter set by B1 and B0 (Mode 7)



DP8408 Interface Between System & DRAM Banks

## **Block Diagram**

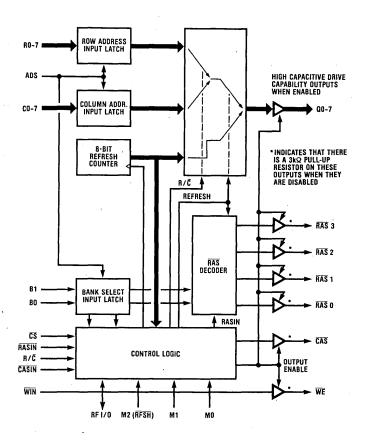
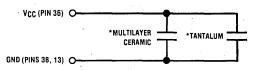


Table 1. DP8408 Mode Select Options

Mode	(RFSH) M2	M1	мо	Mode of Operation	Conditions
0	0	0	0		
1	0	0	1	Externally Controlled Refresh	RF I/O = EOC
2	0	1	0		
3	0	1	1	Externally Controlled All-RAS Write	AII-RAS Active
4	1 ,	0	0	Externally Controlled Access	Active RAS defined by Table 2
5	1	0	1	Auto Access, Slow t <sub>RAH</sub>	Active RAS defined by Table 2
6	1	1	0	Auto Access, Fast t <sub>RAH</sub>	Active RAS defined by Table 2
7	1	1	1	Set End of Count	See Table 3 for Mode 7

#### **Pin Definitions**

 $V_{CC}$ , GND, GND —  $V_{CC}$  = 5V ± 5%. The three supply pins have been assigned to the center of the package to reduce voltage drops, both DC and AC. There are also two ground pins to reduce the low level noise. The second ground pin is located two pins from  $V_{CC}$ , so that decoupling capacitors can be inserted directly next to these pins. It is important to adequately decouple this device, due to the high switching currents that will occur when all 8 address bits change in the same direction simultaneously. A recommended solution would be a  $1\mu F$  multilayer ceramic capacitor in parallel with a low-voltage tantalum capacitor, both connected as close as possible to pins 36 and 38 to reduce lead inductance. See Figure below.



\*Capacitor values should be chosen depending on the particular application.

R0-R7: Row Address Inputs.

C0-C7: Column Address Inputs.

Q0-Q7: Multiplexed Address Outputs — Selected from the Row Address Input Latch, the Column Address Input Latch, or the Refresh Counter.\*

RASIN: Row Address Strobe Input — Enables selected RAS<sub>n</sub> output when M2 (RFSH) is high, or all RAS<sub>n</sub> outputs when RFSH is low.

R/C: Row/Column Select Input — Selects either the row or column address input latch onto the output bus.

CASIN: Column Address Strobe Input — Inhibits CAS output when high in Modes 4 and 3. In Mode 6 it can be used to prolong CAS output.

ADS: Address (Latch) Strobe Input — Row Address, Column Address, and Bank Select Latches are fall-through with ADS high; Latches on high-to-low transition.

CS: Chip Select Input — TRI-STATE's the Address Outputs and puts the control signal into a high-impedance logic "1" state when high (except in Mode 0); enables all outputs when low.

M0, M1, M2: Mode Control Inputs — These 3 control pins determine the 6 major modes of operation of the DP8408 as depicted in Table 1.

RF I/O — The I/O pin functions as a Reset Counter Input when set low from an external open-collector gate, or as a flag output. The flag goes active-low when M2 = 0 and the End-of-Count output is at 127 or 255 (see Table 3).

WIN: Write Enable Input.

WE: Write Enable Output — Buffered output from WIN.\*

CAS: Column Address Strobe Output — In Modes 5 and 6, CAS goes low following valid column address. In Modes 3 and 4, it transitions low after R/C goes low, or follows CASIN going low if R/C is already low. CAS is high during refresh.\*

RAS 0-3: Row Address Strobe Outputs — Selects a memory bank decoded from B1 and B0 (see Table 2), if RESH is high. If RESH is low, all banks are selected.\*

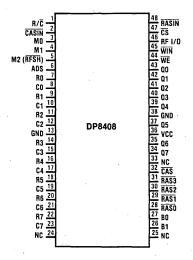
B0, B1: Bank Select Inputs — Strobed by ADS. Decoded to enable one of the RAS outputs when RASIN goes low. Also used to define End-of-Count in Mode 7 (Table 3).

\*These outputs may need damping resistors to prevent overshoot, undershoot. See AN-305 "Precautions to Take When Driving Memories."

Table 2. Memory Bank Decode

	Select d by ADS)	Enabled DAC
B1	В0	Enabled RAS <sub>n</sub>
0	. 0	RAS <sub>0</sub>
0	1	RAS <sub>1</sub>
1	0	RAS <sub>2</sub>
1	1	RAS <sub>3</sub>

#### **Connection Diagram**



NC = NO CONNECTION

Order Number DP8408N, DP8408N-2 DP8408N-3, DP8408D, DP8408D-2 or DP8408D-3 See NS Package N48A or D48A

#### Conditions for all Modes

#### Input Addressing

The address block consists of a row-address latch, a column-address latch, and a resettable refresh counter. The address latches are fall-through when ADS is high and latch when ADS goes low. If the address bus contains valid addresses until after the valid address time, ADS can be permanently high. Otherwise ADS must go low while the addresses are still valid.

In normal memory access operation,  $\overline{\text{RASIN}}$  and  $\overline{\text{R/C}}$  are initially high. When the address inputs are enabled into the address latches, the row addresses appear on the Q outputs. The address strobe also inputs the bank-select address, (B0 and B1). If  $\overline{\text{CS}}$  is low, all outputs are enabled. When  $\overline{\text{CS}}$  is transitioned high, the address outputs go TRI-STATE and the control outputs first go high through a low impedance, and then are held by an onchip high impedance. This allows output paralleling with other DP8408s for multi-addressing. All outputs go active about 50 ns after the chip is selected again. If  $\overline{\text{CS}}$  is high, and a refresh cycle begins, all the outputs become active until the end of the refresh cycle.

#### **Drive Capability**

The DP8408 has timing parameters that are specified with up to 600 pF loads. In a typical memory system this is equivalent to about 88, 5V-only DRAMs, with trace lengths kept to a minimum. Therefore, the chip can drive four banks each of 16 or 22 bits, or two banks of 32 or 39 bits, or one bank of 64 or 72 bits.

Less loading will slightly reduce the timing parameters, and more loading will increase the timing parameters, according to the graph of Figure 6. The AC performance parameters are specified with the typical load capacitance of 88 DRAMs. This graph can be used to extrapolate the variations expected with other loading.

Because of distributed trace capacitance and inductance and DRAM input capacitance, current spikes can be created, causing overshoots and undershoots at the DRAM inputs that can change the contents of the DRAMs or even destroy them. To remove these spikes, a damping resistor (low inductance, carbon) can be inserted between the DP8408 driver outputs and the DRAMs, as close as possible to the DP8408. The values of the damping resistors may differ between the different control outputs; RAS's CAS, Q's and WE. The damping resistors should be determined by the first prototypes (not wire-wrapped due to larger distributed capacitance and inductance). The best values for the damping resistors are the critical values giving a critically damped transition on the control outputs. Typical values for the damping resistors will be between  $15\Omega$  and  $100\Omega$ , the lower the loading the higher the value. (For more information, see AN-305 "Precautions to Take When Driving Memories.")

#### DP8408 Driving any 16k or 64k DRAMs

The DP8408 can drive any 16k or 64k DRAMs. All 16k DRAMs are basically the same configuration, including the newer 5V-only version. Hence, in most applications, different manufacturers' DRAMs are interchangeable (for the same supply-rail chips), and the DP8408 can drive all 16k DRAMs (see Figure 1a).

There are three basic configurations for the 5V-only 64k DRAMs: a 128-row by 512-column array with an on-RAM refresh counter, a 128-row by 512-column array with no on-RAM refresh counter, and a 256-row by 256-column array with no on-RAM refresh counter. The DP8408 can drive all three configurations, and at the same time allows them all to be interchangeable (as shown in Figures 1b and 1c), providing maximum flexibility in the choice of DRAMs. Since the 8-bit on-chip refresh counter can be used as a 7-bit refresh counter for the 128-row configuration, or as an 8-bit refresh counter for the 256-row configuration, the on-RAM refresh counter (if present) is never used. As long as 128 rows are refreshed every 2ms (i.e. 256 rows in 4ms) all DRAM types are correctly refreshed.

When the DP8408 is in a refresh mode, the RF I/O pin indicates that the on-chip refresh counter has reached its end-of-count. This end-of-count is selectable as 127 or 255 to accommodate 16k or 64k DRAMs, respectively. Although the end-of-count may be chosen to be either of these values, the counter is not reset and always counts to 255 before rolling over to zero.

#### Read, Write, and Read-Modify-Write Cycles

The output signal,  $\overline{WE}$ , determines what type of memory access cycle the memory will perform. If  $\overline{WE}$  is kept high while  $\overline{CAS}$  goes low, a read cycle occurs. If  $\overline{WE}$  goes low before  $\overline{CAS}$  goes low, a write cycle occurs and data at DI (DRAM input data) is written into the DRAM as  $\overline{CAS}$  goes low. If  $\overline{WE}$  goes low later than  $t_{CWD}$  after  $\overline{CAS}$  goes low, first a read occurs and DO (DRAM output data) becomes valid; then data DI is written into the same address in the DRAM when  $\overline{WE}$  goes low. In this readmodify-write case, DI and DO cannot be linked together. The type of cycle is therefore controlled by  $\overline{WE}$ , which follows  $\overline{WIN}$ .

#### Power-Up Initialize

When  $V_{CC}$  is first applied to the DP8408, an initialize pulse clears the refresh counter, the internal control flip-flops, and sets the End-of-Count of the refresh counter to 127 (which may be changed via Mode 7). As  $V_{CC}$  increases to about 2.3 volts, it holds the output control signals at a level of one Schottky diode-drop below  $V_{CC}$ , and the output address to TRI-STATE. As  $V_{CC}$  increases above 2.3 volts, control of these outputs is granted to the system.

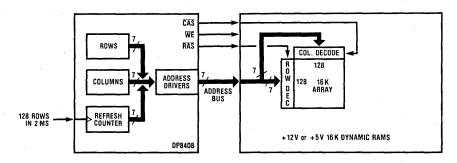


FIGURE 1a. DP8408 with any 16k DRAMS

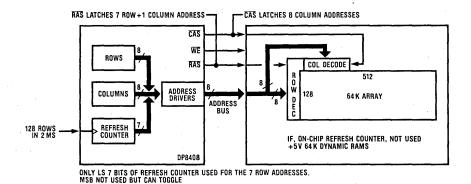


FIGURE 1b. DP8408 with 128 Row × 512 Column 64k DRAM

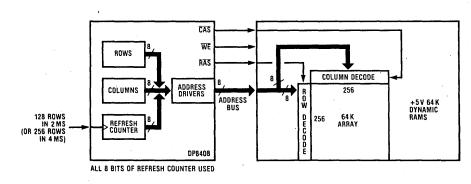


FIGURE 1c. DP8408 with 256 × 256 Column 64k DRAM

## DP8408 Functional Mode Descriptions

Note: All delay parameters stated in text refer to the DP8408. Substitute the respective delay numbers for the DP8408-2 or DP8408-3 when using these devices.

#### Modes 0,1,2 - Externally Controlled Refresh

In this mode, the input address latches are disabled from the address outputs and the refresh counter is enabled. When RAS occurs, the enabled row in the DRAM is refreshed. In the Externally Controlled Refresh mode, all RAS outputs are enabled following RASIN, and CAS is inhibited. This refreshes the same row in all four banks. The refresh counter increments when either RASIN or RFSH goes low-to-high after a refresh. RF I/O goes low when the count is 127 or 255, as set by End-of-Count (see Table 3), with RASIN and RFSH low. To reset the counter to all zeroes, RF I/O is set low through an external open-collector driver.

During refresh, RASIN and RFSH must be skewed transitioning low such that the refresh address is valid on the address outputs of the controller before the RAS outputs go low. The amount of time that RFSH should

go low before  $\overline{\text{RASIN}}$  does depends on the capacitive loading of the address and  $\overline{\text{RAS}}$  lines. For the load specified in the switching characteristics of this data sheet, 10ns is sufficient. Refer to Figure 2.

To perform externally controlled burst refresh, RASIN is toggled while RFSH is held low. The refresh counter increments with RASIN going low to high, so that the DRAM rows are refreshed in succession by RASIN going high to low.

#### Mode 3 — Externally Controlled All-RAS Write

This mode is useful at system initialization. The memory address is provided by the processor, which also performs the incrementing. All four  $\overline{\text{RAS}}$  outputs follow RASIN (supplied by the processor), strobing the row address into the DRAMs. R/ $\overline{\text{C}}$  can now go low, while CASIN may be used to control  $\overline{\text{CAS}}$  (as in the Externally Controlled Access mode), so that  $\overline{\text{CAS}}$  strobes the column address contents into the DRAMs. At this time  $\overline{\text{WE}}$  should be low, causing the data to be written into all four banks of DRAMs. At the end of the write cycle, the input address is incremented and latched by the DP8408 for the next write cycle.

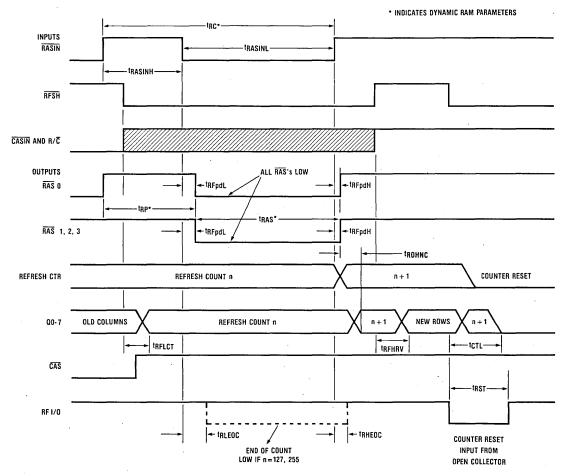


FIGURE 2. External Control Refresh Cycle (MODES 0,1,2)

#### Mode 4 — Externally Controlled Access

This mode facilitates externally controlling all accesstiming parameters associated with the DRAMs. The application of modes 0 and 4 are shown in Figure 3.

#### **Output Address Selection**

Refer to Figure 4a. With M2 (RFSH) and R/C high, the row address latch contents are transferred to the multiplexed address bus output Q0-Q7, provided  $\overline{CS}$  is set low. The column address latch contents are output after R/C goes low.  $\overline{RASIN}$  can go low after the row addresses have been set up on Q0-Q7. This selects one of the  $\overline{RAS}$  outputs, strobing the row address on the Q outputs into the desired bank of memory. After the row-address hold-time of the DRAMs, R/C can go low so that about 40 ns later column addresses appear on the Q outputs.

#### Automatic CAS Generation

In a normal memory access cycle  $\overline{\text{CAS}}$  can be derived from inputs  $\overline{\text{CASIN}}$  or  $\overline{\text{R/C}}$ . If  $\overline{\text{CASIN}}$  is high, then  $\overline{\text{R/C}}$ 

going low switches the address output drivers from rows to columns.  $\overline{CASIN}$  then going low causes  $\overline{CAS}$  to go low approximately 40 ns later, allowing  $\overline{CAS}$  to occur at a predictable time (see Figure 4b). If  $\overline{CASIN}$  is low when  $R/\overline{C}$  goes low,  $\overline{CAS}$  will be automatically generated, following the row to column transition by about 20 ns (see Figure 4a).  $\overline{Most}$  DRAMs have a column address set-up time before  $\overline{CAS}$  (t<sub>ASC</sub>) of 0 ns or - 10 ns. In other words, a t<sub>ASC</sub> greater than 0 ns is safe. This feature reduces timing-skew problems, thereby improving access time of the system.

#### **Fast Memory Access**

AC parameters  $t_{DIF1}$ ,  $t_{DIF2}$  may be used to determine the minimum delays required between  $\overline{RASIN}$ ,  $R/\overline{C}$ , and  $\overline{CASIN}$  (see Application Brief 9; "Fastest DRAM Access Mode").

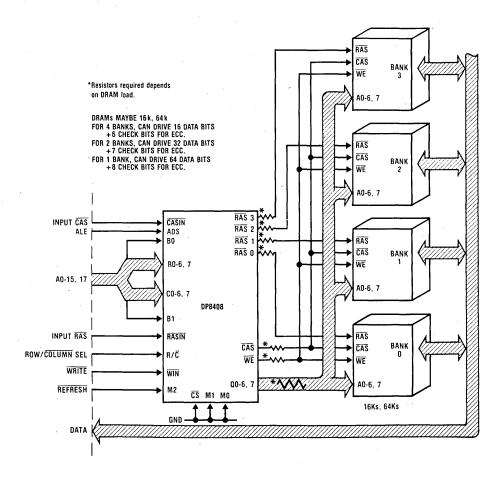


FIGURE 3. Typical Application of DP8408 Using Externally Controlled Access and Refresh in Modes 0 and 4

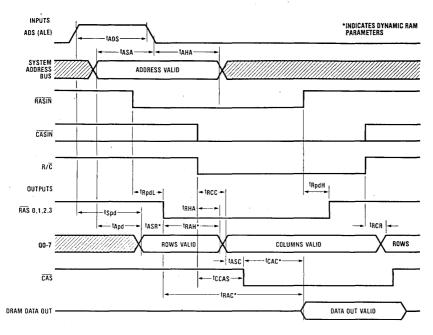


FIGURE 4a. Read Cycle Timing (Mode 4)

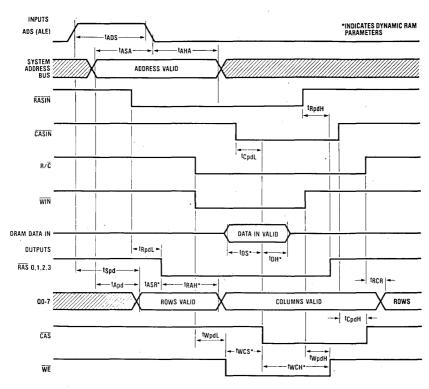


FIGURE 4b. Write Cycle Timing (Mode 4)

#### Mode 5 — Automatic Access

The Auto Access mode has two advantages over the Externally Controlled Access mode, due to the fact that all outputs except WE are initiated from RASIN. First, inputs R/C and CASIN are unnecessary. Secondly, because the output control signals are derived internally from one input signal (RASIN), timing-skew problems are reduced, thereby reducing memory access time substantially or allowing use of slower DRAMs. The automatic access features of Mode 5 (and Mode 6) of the DP8408 make DRAM accessing appear essentially "static".

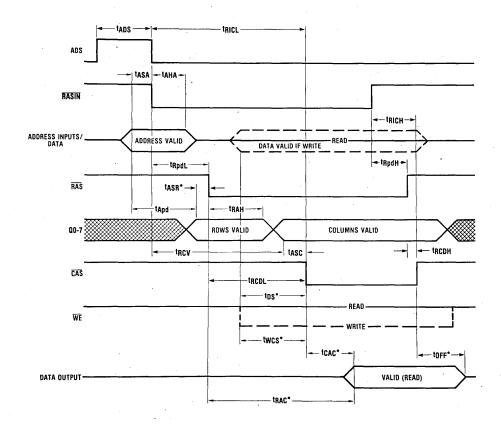
#### **Automatic Access Control**

The major disadvantage of DRAMs compared to static RAMs is the complex timing involved. First, a RAS must occur with the row address previously set up on the multiplexed address bus. After the row address has been

held for  $t_{\rm RAH}$ , (the Row-Address hold-time of the DRAM), the column address is set up and then  $\overline{\rm CAS}$  occurs. This is all performed automatically by the DP8408 in this mode.

Provided the input address is valid as ADS goes low,  $\overline{\text{RASIN}}$  can go low any time after ADS. This is because the selected  $\overline{\text{RAS}}$  occurs typically 27 ns later, by which time the row address is already valid on the address output of the DP8408. The Address Set-Up time ( $t_{\text{ASR}}$ ), is 0 ns on most DRAMs. The DP8408 in this mode (with ADS and  $\overline{\text{RASIN}}$  edges simultaneously applied) produces a minimum  $t_{\text{ASR}}$  of 0 ns. This is true provided the input address was valid  $t_{\text{ASA}}$  before ADS went low (see Figure 5a).

Next, the row address is disabled after  $t_{RAH}$  (30 ns minimum); in most DRAMs,  $t_{RAH}$  minimum is less than 30 ns. The column address is then set up and  $t_{ASC}$  later,  $\overline{CAS}$ 



<sup>\*</sup>INDICATES DYNAMIC RAM PARAMETERS

FIGURE 5a. Modes 5, 6 Timing (CASIN High in Mode 6

occurs. The only other control input required is WIN. When a write cycle is required, WIN must go low at least 30ns before CAS is output low.

This gives a total typical delay from: input address valid to RASIN (15ns); to RAS (27ns); to rows held (50ns); to columns valid (25ns); to CAS (23ns) = 140ns (that is, 125ns from RASIN). All of these typical figures are for heavy capacitive loading, of approximately 88 DRAMs. This mode is therefore extremely fast. The external timing is greatly simplified for the memory system designer: the only system signal required is RASIN.

#### Mode 6 - Fast Automatic Access

The Fast Access mode is similar to Mode 5, but has a faster t<sub>RAH</sub> of 20 ns, minimum. It therefore can only be used with fast 16k or 64k DRAMs (which have a tRAH of 10 ns to 15 ns) in applications requiring fast access times; RASIN to CAS is typically 105 ns.

In this mode, the R/C pin is not used, but CASIN is used to allow an extended CAS after RAS has already terminated. Refer to Figure 5b. This is desirable with fast cycle-times where RAS has to be terminated as soon as possible before the next RAS begins (to meet the precharge time, or t<sub>RP</sub>, requirements of the DRAM). CAS may then be held low by CASIN to extend the data output valid time from the DRAM to allow the system to read the data. CASIN subsequently going high ends CAS. If this extended CAS is not required, CASIN should be set high in Mode 6.

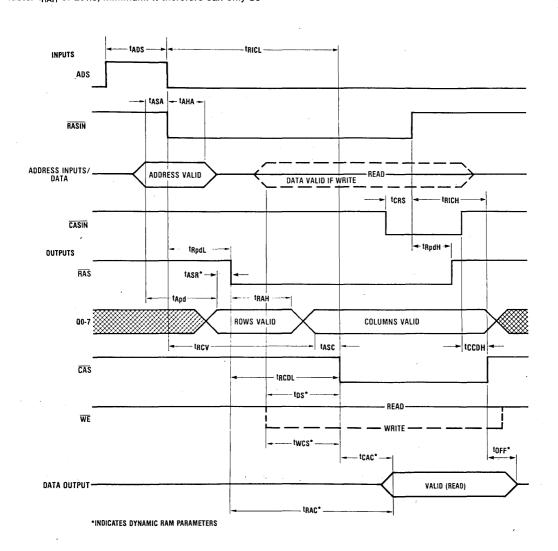


FIGURE 5b. Mode 6 Timing, Extended CAS

#### Mode 7 - Set End-of-Count

The End-of-Count can be externally selected in Mode 7, using ADS to strobe in the respective value of B1 and B0 (see Table 3). With B1 and B0 the same EOC is 127; with B1 = 0 and B0 = 1, EOC is 255; and with B1 = 1 and B0 = 0, EOC is 127. This selected value of EOC will be used until the next Mode 7 selection. At power-up the EOC is automatically set to 127 (B1 and B0 set to 11).

Table 3. Mode 7

Bank Select (Strobed by ADS)		End of Count
B1	В0	Selected
0	0	127
0	1	255
1	0	127
1	1	127

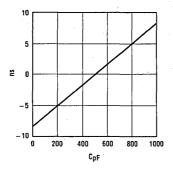


FIGURE 6. Change in Propagation Delay vs. Loading Capacitance Relative to a 500pF Load

3542mW

2833mW

#### **Absolute Maximum Ratings** (Note 1)

Supply Voltage, V<sub>CC</sub> 7.0V Storage Temperature Range -65°C to +150°C Input Voltage 5.5V Output Current 150 mA Lead Temperature (Soldering, 10 seconds) 300°C

\*Derate cavity package 23.6mW/°C above 25°C; derate molded package 22.7mW/°C above 25°C.

Maximum Power Dissipation\* at 25°C Cavity Package Molded Package

**Operating Conditions** 

Electrical Characteristics V<sub>CC</sub> = 5.0V ± 5%, 0°C ≤ T<sub>A</sub> ≤ 70°C unless otherwise noted (Notes 2, 6)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>C</sub>	Input Clamp Voltage	$V_{CC} = Min., I_C = -12 \text{ mA}$		-0.8	-1.2	٧
l <sub>IH1</sub>	Input High Current for ADS, R/C only	V <sub>IN</sub> = 2.5V		2.0	100	μΑ
I <sub>IH2</sub>	Input High Current for All Other Inputs*	V <sub>IN</sub> = 2.5V		1.0	50	μΑ
I <sub>I</sub> RSI	Output Load Current for RF I/O	V <sub>IN</sub> = 0.5V, Output High		-1.5	-2.5	mA
I <sub>I</sub> CTL	Output Load Current for RAS, CAS, WE	V <sub>IN</sub> = 0.5V, Chip Deselect		-1.5	-2.5	mA
l <sub>IL1</sub>	Input Low Current for ADS, R/C only	V <sub>IN</sub> = 0.5V		-0.1	-1.0	mA
I <sub>IL2</sub>	Input Low Current for All Other Inputs*	V <sub>IN</sub> = 0.5V		-0.05	-0.5	mA
V <sub>IL</sub>	Input Low Threshold				0.8	٧
V <sub>IH</sub>	Input High Threshold		2.0			٧
V <sub>OL1</sub>	Output Low Voltage*	I <sub>OL</sub> = 20 mA		0.3	0.5	٧
V <sub>OL2</sub>	Output Low Voltage for RF I/O	I <sub>OL</sub> = 10 mA		0.3	0.5	٧
V <sub>OH1</sub>	Output High Voltage*	I <sub>OH</sub> = -1 mA	2.4	3.5		V
V <sub>OH2</sub>	Output High Voltage for RF I/O	$I_{OH} = -100\mu A$	2.4	3.5		٧
I <sub>1D</sub>	Output High Drive Current*	V <sub>OUT</sub> = 0.8V (Note 3)		-200		mA
I <sub>OD</sub>	Output Low Drive Current*	V <sub>OUT</sub> = 2.7V (Note 3)		200		mA
loz	TRI-STATE Output Current (Address Outputs)	0.4V ≤ V <sub>OUT</sub> ≤ 2.7V, <del>CS</del> = 2.0V, Mode 4	-50	1.0	50	μА
Icc	Supply Current	V <sub>CC</sub> = Max.		210	285	mA

<sup>\*</sup>Except RF I/O Output.

Switching Characteristics: DP8408/DP8408-3  $V_{CC}=5.0V\pm5\%$ , 0°C  $\leq T_A \leq 70$ °C unless otherwise noted (Notes 2, 4, 5). The output load capacitance is typical for 4 banks of 22 DRAMs each or 88 DRAMs including trace capacitance. These values are: Q0-Q7,  $C_L=500\,\mathrm{pF}$ ; RAS0-RAS3,  $C_L=150\,\mathrm{pF}$ ; WE,  $C_L=500\,\mathrm{pF}$ ; CAS,  $C_L=600\,\mathrm{pF}$ , unless otherwise noted. See Figure 7 for test load. Switches S1 and S2 are closed unless otherwise noted, and R1 and R2 are  $4.7k\Omega$  unless otherwise noted. Maximum propagation delays are specified with all outputs switching.

Acces Barrenston	<b></b>	8408			8408 – 3			
Access Parameter	Conditions		Тур	Max	Min	Тур	Max	Units
RASIN to CAS Output Delay (Mode 5)	Figure 5a	95	125	160	95	125	185	ns
RASIN to CAS Output Delay (Mode 6)	Figures 5a, 5b	80	105	140	80	105	160	ns
RASIN to CAS Output Delay (Mode 5)	Figure 5a	40	48	60	40	48	70	ns
RASIN to CAS Output Delay (Mode 6)	Figures 5a, 5b	50	63	80	50	63	95	ns
RAS to CAS Output Delay (Mode 5)	Figure 5a		98	125		98	145	ns
RAS to CAS Output Delay (Mode 6)	Figures 5a, 5b		78	105		78	120	ns
RAS to CAS Output Delay (Mode 5)	Figure 5a		27	40		27	40	ns
RAS to CAS Output Delay (Mode 6)	Figure 5a		40	65		40	65	ns
CASIN to CAS Output Delay (Mode 6)	Figure 5b	40	54	70	40	54	80	ns
Row Address Hold Time (Mode 5)	Figure 5a	30			30			ns
Row Address Hold Time (Mode 6)	Figures 5a, 5b	20			20			ns
Column Address Setup Time (Mode 5)	Figure 5a	8			8			ns
Column Address Setup Time (Mode 6)	Figures 5a, 5b	6			6			ns
RASIN to Column Address Valid (Mode 5)	Figure 5a		90	120		90	140	ns
	RASIN to CAS Output Delay (Mode 6) RASIN to CAS Output Delay (Mode 5) RASIN to CAS Output Delay (Mode 6) RAS to CAS Output Delay (Mode 6) RAS to CAS Output Delay (Mode 6) RAS to CAS Output Delay (Mode 6) RAS to CAS Output Delay (Mode 6) CASIN to CAS Output Delay (Mode 6) CASIN to CAS Output Delay (Mode 6) Row Address Hold Time (Mode 5) Row Address Hold Time (Mode 6) Column Address Setup Time (Mode 5) Column Address Setup Time (Mode 6) RASIN to Column Address Valid	RASIN to CAS Output Delay (Mode 5)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 5)  RASIN to CAS Output Delay (Mode 5)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 5)  RAS to CAS Output Delay (Mode 5)  RAS to CAS Output Delay (Mode 6)  RAS to CAS Output Delay (Mode 5)  RAS to CAS Output Delay (Mode 5)  RAS to CAS Output Delay (Mode 6)  RAS to CAS Output Delay (Mode 6)  RAS to CAS Output Delay (Mode 6)  RAS to CAS Output Delay (Mode 6)  ROW Address Hold Time (Mode 5)  Row Address Hold Time (Mode 6)  Column Address Setup Time (Mode 5)  Figure 5a  Column Address Setup Time (Mode 6)  RASIN to Column Address Valid  Figure 5a	RASIN to CAS Output Delay (Mode 5)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 5)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 5)  RAS to CAS Output Delay (Mode 5)  RAS to CAS Output Delay (Mode 6)  RAS to CAS Output Delay (Mode 5)  RAS to CAS Output Delay (Mode 6)  RAS to CAS Output Delay (Mode 6)  RAS to CAS Output Delay (Mode 6)  RAS to CAS Output Delay (Mode 6)  RAS to CAS Output Delay (Mode 6)  Figure 5a  CASIN to CAS Output Delay (Mode 5)  Row Address Hold Time (Mode 5)  Row Address Hold Time (Mode 6)  Figure 5a  8  Column Address Setup Time (Mode 6)  Figure 5a, 5b  6  RASIN to Column Address Valid	Access Parameter  Conditions  Min Typ  RASIN to CAS Output Delay (Mode 5)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 5)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 5)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 6)  RASIN to CAS Output Delay (Mode 6)  ROW Address Hold Time (Mode 5)  Row Address Hold Time (Mode 6)  Row Address Setup Time (Mode 6)  RASIN to Column Address Valid  Figure 5a  8  POURTH Typ  Min Typ  Min Typ  Min Typ  Min Typ  Min Typ  125  Roy	Access Parameter         Conditions         Min         Typ         Max           RASIN to CAS Output Delay (Mode 5)         Figure 5a         95         125         160           RASIN to CAS Output Delay (Mode 6)         Figures 5a, 5b         80         105         140           RASIN to CAS Output Delay (Mode 5)         Figure 5a         40         48         60           RASIN to CAS Output Delay (Mode 6)         Figures 5a, 5b         50         63         80           RAS to CAS Output Delay (Mode 5)         Figure 5a         98         125           RAS to CAS Output Delay (Mode 6)         Figure 5a         27         40           RAS to CAS Output Delay (Mode 6)         Figure 5a         40         65           CASIN to CAS Output Delay (Mode 6)         Figure 5a         30         40           Row Address Hold Time (Mode 5)         Figure 5a         30         40           Row Address Hold Time (Mode 6)         Figure 5a         8         40           Column Address Setup Time (Mode 6)         Figure 5a, 5b         6         6           RASIN to Column Address Valid         Figure 5a         90         120	Access Parameter         Conditions         Min         Typ         Max         Min           RASIN to CAS Output Delay (Mode 5)         Figure 5a         95         125         160         95           RASIN to CAS Output Delay (Mode 6)         Figures 5a, 5b         80         105         140         80           RASIN to CAS Output Delay (Mode 5)         Figure 5a         40         48         60         40           RAS to CAS Output Delay (Mode 6)         Figure 5a         98         125           RAS to CAS Output Delay (Mode 6)         Figures 5a, 5b         78         105           RAS to CAS Output Delay (Mode 6)         Figure 5a         27         40           RAS to CAS Output Delay (Mode 6)         Figure 5a         40         65           CASIN to CAS Output Delay (Mode 6)         Figure 5a         30         30           Row Address Hold Time (Mode 5)         Figure 5a         30         30           Row Address Hold Time (Mode 6)         Figure 5a         8         8           Column Address Setup Time (Mode 6)         Figure 5a, 5b         6         6           RASIN to Column Address Valid         Figure 5a         90         120	Access Parameter         Conditions         Min         Typ         Max         Min         Typ           RASIN to CAS Output Delay (Mode 5)         Figure 5a         95         125         160         95         125           RASIN to CAS Output Delay (Mode 6)         Figures 5a, 5b         80         105         140         80         105           RASIN to CAS Output Delay (Mode 5)         Figure 5a         40         48         60         40         48           RAS to CAS Output Delay (Mode 6)         Figure 5a         98         125         98           RAS to CAS Output Delay (Mode 6)         Figure 5a         27         40         27           RAS to CAS Output Delay (Mode 6)         Figure 5a         40         65         40           CASIN to CAS Output Delay (Mode 6)         Figure 5a         40         54         70         40         54           Row Address Hold Time (Mode 5)         Figure 5a         30         30         30           Row Address Hold Time (Mode 6)         Figure 5a         8         8           Column Address Setup Time (Mode 6)         Figure 5a         8         8           RASIN to Column Address Valid         Figure 5a         90         120         90	Access Parameter         Conditions         Min         Typ         Max         Min         Typ         Max           RASIN to CAS Output Delay (Mode 5)         Figure 5a         95         125         160         95         125         185           RASIN to CAS Output Delay (Mode 6)         Figures 5a, 5b         80         105         140         80         105         160           RASIN to CAS Output Delay (Mode 5)         Figure 5a         40         48         60         40         48         70           RAS to CAS Output Delay (Mode 6)         Figure 5a         98         125         98         145           RAS to CAS Output Delay (Mode 6)         Figure 5a         27         40         27         40           RAS to CAS Output Delay (Mode 6)         Figure 5a         40         65         40         65           CASIN to CAS Output Delay (Mode 6)         Figure 5a         40         54         70         40         54         80           Row Address Hold Time (Mode 5)         Figure 5a         30         30         30         30         30         30         30         30         30         30         30         30         30         30         30         30         30

## Switching Characteristics (Cont'd)

Symbol	Access Parameter	Conditions	<u> </u>	8408			408 –		Units
	Access Farameter	Conditions	Min.	Тур	Max	Min	Тур	Max	
t <sub>RCV</sub>	RASIN to Column Address Valid (Mode 6)	Figures 5a, 5b	,	75	105		75	120	ns
t <sub>RPDL</sub>	RASIN to RAS Delay	Figures 4a, 4b, 5a, 5b	20	27	35	20	27	40	ns
t <sub>RPDH</sub>	RASIN to RAS Delay Figures 4a, 4b, 5a, 5b		15	23	32	15	23	37	ns
tAPDL	Address Input to Output Low Delay Figures 4a, 4b, 5a, 5b			25	40		25	46	ns
tAPDH	Address Input to Output High Delay	Figures 4a, 4b, 5a, 5b		25	40		25	46	ns
t <sub>SPDL</sub>	Address Strobe to Address Output Low	Figures 4a, 4b		40	60		40	70	ns
t <sub>SPDH</sub>	Address Strobe to Address Output High	Figures 4a, 4b		40	60		40	70	ns
t <sub>ASA</sub>	Address Setup Time to ADS	Figures 4a, 4b, 5a, 5b	15			15			ns
t <sub>AHA</sub>	Address Hold Time from ADS	Figures 4a, 4b, 5a, 5b	15			15			ns
t <sub>ADS</sub>	Address Strobe Pulse Width	Figures 4a, 4b, 5a, 5b	30			30			ns
twppl	WIN to WE Output Delay	Figure 4b	15	25	30	15	25	35	ns
twent	WIN to WE Output Delay	Figure 4b	15	30	60	15	30	70	ns
tors	CASIN Setup Time to RASIN High (Mode 6)	Figure 5b	35	- 50		35		- <u>-</u> -	ns
	CASIN to CAS Delay (R/C low in Mode 4)	Figure 4b	32	41	68	32	41	77	ns
toppl	CASIN to CAS Delay	Figure 4b	25	39	50	25	39	60	ns
t <sub>CPDH</sub>	Column Select to Column Address Valid		25	40	58	20	40	67	-
t <sub>RCC</sub>		Figure 4a	<del> </del>	40	58		40	67	ns
tRCR	Row Select to Row Address Valid	Figures 4a, 4b	10	40	56	10	40	07	ns
TRHA	Row Address Held from Column Select	Figure 4a	10			10			ns
t <sub>CCAS</sub>	R/C Low to CAS Low (Mode 4 Auto CAS)	Figure 7a	ļ	65	90				ns
t <sub>DIF1</sub>	Maximum (t <sub>RPDL</sub> – t <sub>RHA</sub> )	See Mode 4 description			13			18	ns
t <sub>DIF2</sub>	Maximum (t <sub>RCC</sub> – t <sub>CPDL</sub> )	See Mode 4 description			13			18	ns
	Refresh Parameter								
t <sub>RC</sub>	Refresh Cycle Period	Figure 2	100			100			ns
t <sub>RASINL,H</sub>	Pulse Width of RASIN during Refresh	Figure 2	50			50			ns
t <sub>RFPDL</sub>	RASIN to RAS Delay during Refresh	Figure 2	35	50	70	35	50	80	ns
tREPDH	RASIN to RAS Delay during Refresh	Figure 2	30	40	55.	30	40	65	ns
t <sub>RFLCT</sub>	RFSH Low to Counter Address Valid	CS = X, Figure 2	<del> </del>	47	60		47	70	ns
tREHBY	RFSH High to Row Address Valid	Figure 2	<del> </del>	45	60		45	70	ns
tROHNC	RAS High to New Count Valid	Figure 2	-	30	. 55		30	55	ns
t <sub>RLEOC</sub>	RASIN Low to End-of-Count Low	C <sub>L</sub> = 50pF, Figure 2	ļ	-	80			80	ns
	RASIN High to End-of-Count High	$C_L = 50 \text{ pF}, \text{ Figure 2}$			80			- 80	ns
t <sub>RHEOC</sub>	Counter Reset Pulse Width	Figure 2	70		- 60	70		- 00	
TRST			1 70		100	10		100	ns
t <sub>CTL</sub>	RF I/O Low to Counter Outputs All Low	Figure 2			100	L		100	ns
	TRI-STATE Parameter	· · · · · · · · · · · · · · · · · · ·	<u> </u>			1		т	
t <sub>zH</sub>	CS Low to Address Output High from Hi-Z	Figure 8 R1 = 3.5k, R2 = 1.5k		35	60		35	60	ns
t <sub>HZ</sub>	CS High to Address Output Hi-Z from High	C <sub>L</sub> = 15pF, Figure 8 R2 = 1k, S1 open		20	40		20	40	ns
tzL	CS Low to Address Output Low from Hi-Z	Figure 8 R1 = 3.5k, R2 = 1.5k		35	60		35	60	n
t <sub>LZ</sub>	CS High to Address Output Hi-Z from Low	C <sub>L</sub> = 15 pF, Figure 8, R1 = 1 k, S2 open		25	50		25	50	ns

#### Switching Characteristics (Cont'd)

0	TDI OTATE Description		8408			8	]		
Symbol	TRI-STATE Parameter	TRI-STATE Parameter Conditions					Тур	Max	Units
t <sub>HZH</sub>	CS Low to Control Output High from Hi-Z High	Figure 8 R2 = 750Ω, S1 open		50	80		50	80	ns
t <sub>HHZ</sub>	CS High to Control Output Hi-Z High from High	$C_L = 15 pF$ , Figure 8 R2 = 750 $\Omega$ , S1 open		40	75		40	75	ns
t <sub>HZL</sub>	CS Low to Control Output Low from Hi-Z High	Figure 8 S1, S2 open		45	75		45	75	ns
t <sub>LHZ</sub>	CS High to Control Output Hi-Z High from Low	$C_L = 15 pF$ , Figure 8, $R2 = 750 \Omega$ , S1 open		50	80		50	80	ns

**Switching Characteristics: DP8408–2**  $V_{CC} = 5.0V \pm 5\%$ ,  $0^{\circ}C \le T_{A} \le 70^{\circ}C$  unless otherwise noted (Notes 2, 4, 5, 7). The output load capacitance is typical for 4 banks of 22 DRAMs each or 88 DRAMs including trace capacitance. These values are: Q0–Q7,  $C_L = 500\,\mathrm{pF}$ ; RAS0–RAS3,  $C_L = 150\,\mathrm{pF}$ ; WE,  $C_L = 500\,\mathrm{pF}$ ; CAS,  $C_L = 600\,\mathrm{pF}$ , unless otherwise noted. See Figure 7 for test load. Switches S1 and S2 are closed unless otherwise noted, and R1 and R2 are 4.7kΩ unless otherwise noted. Maximum propagation delays are specified with all outputs switching.

	Access Bourneston		8	408 -	2				
Symbol	Access Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
tRICL	RASIN to CAS Output Delay (Mode 5)	Figure 5a	75	100	130				ns
tRICL	RASIN to CAS Output Delay (Mode 6)	Figures 5a, 5b	65	90	115				ns
t <sub>RICH</sub>	RASIN to CAS Output Delay (Mode 5)	Figure 5a	40	48	60				ns
t <sub>RICH</sub>	RASIN to CAS Output Delay (Mode 6)	Figures 5a, 8b	50	63	80				ns
t <sub>RCDL</sub>	RAS to CAS Output Delay (Mode 5)	Figure 5a		. 75	100				ns
tRCDL	RAS to CAS Output Delay (Mode 6)	Figures 5a, 5b		65	85				ns
t <sub>RCDH</sub>	RAS to CAS Output Delay (Mode 5)	Figure 5a		27	40				ns
t <sub>RCDH</sub>	RAS to CAS Output Delay (Mode 6)	Figure 5a		40	65				ns
tCCDH	CASIN to CAS Output Delay (Mode 6)	Figure 5b	40	54	70				ns
t <sub>RAH</sub>	Row Address Hold Time (Mode 5) (Note 7)	Figure 5a	20						ns
t <sub>RAH</sub>	Row Address Hold Time (Mode 6) (Note 7)	Figures 5a, 5b	12						ns
tasc	Column Address Setup Time (Mode 5)	Figure 5a	3						ns
tASC	Column Address Setup Time (Mode 6)	Figures 5a, 8b	3						ns
t <sub>RCV</sub>	RASIN to Column Address Valid (Mode 5)	Figure 5a		80	105				ns
t <sub>RCV</sub>	RASIN to Column Address Valid (Mode 6)	Figures 5a, 5b		70	90				ns
t <sub>RPDL</sub>	RASIN to RAS Delay	Figures 4a, 4b, 5a, 5b	20	27	35				ns
t <sub>RPDH</sub>	RASIN to RAS Delay	Figures 4a, 4b, 5a, 5b	15	23	32				ns
tAPDL	Address Input to Output Low Delay	Figures 4a, 4b, 5a, 5b		25	40				ns
tAPDH	Address Input to Output High Delay	Figures 4a, 4b, 5a, 5b		25	40				ns
t <sub>SPDL</sub>	Address Strobe to Address Output Low	Figures 4a, 4b		40	60				ns
t <sub>SPDH</sub>	Address Strobe to Address Output High	Figures 4a, 4b		40	60				ns
t <sub>ASA</sub>	Address Set-up Time to ADS	Figures 4a, 4b, 5a, 5b	15						ns
t <sub>AHA</sub>	Address Hold Time from ADS	Figures 4a, 4b, 5a, 5b	15						ns
t <sub>ADS</sub>	Address Strobe Pulse Width	Figures 4a, 4b, 5a, 5b	30						ns
twppl	WIN to WE Output Delay	Figure 4b	15	25	30				ns
t <sub>WPDH</sub>	WIN to WE Output Delay	Figure 4b	15	30	60				ns
t <sub>CRS</sub>	CASIN Set-up Time to RASIN High (Mode 6)	Figure 5b	35						ns
tCPDL	CASIN to CAS Delay (R/C low in Mode 4)	Figure 4b	32	, 41	- 58				ns

Symbol	Access Parameter	0	88	408 –	2				lle!
Symbol	Access Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
t <sub>CPDH</sub>	CASIN to CAS Delay (R/C low in Mode 4)	Figure 4b	25	39	50				ns
t <sub>RCC</sub>	Column Select to Column Address Valid	Figure 4a		40	58				ns
t <sub>RCR</sub>	Row Select to Row Address Valid	Figures 4a, 4b		40	58				ns
t <sub>RHA</sub>	Row Address Held from Column Select	Figure 4a	10						ns
t <sub>CCAS</sub>	R/C Low to CAS Low (Mode 4 Auto CAS)	Figure 7a		55	75				ns
t <sub>DIF1</sub>	Maximum (t <sub>RPDL</sub> – t <sub>RHA</sub> )	See Mode 4 description			13				ns
t <sub>DIF2</sub>	Maximum (t <sub>RCC</sub> – t <sub>CPDL</sub> )	See Mode 4 description			- 13				ns
	Refresh Parameter					,			
t <sub>RC</sub>	Refresh Cycle Period	Figure 2	100						ns
t <sub>RASINL,H</sub>	Pulse Width of RASIN during Refresh	Figure 2	50						ns
t <sub>RFPDL</sub>	RASIN to RAS Delay during Refresh	Figure 2	35	50	70				ns
t <sub>RFPDH</sub>	RASIN to RAS Delay during Refresh	Figure 2	30	40	55				ns
tRFLCT	RFSH Low to Counter Address Valid	CS = X, Figure 2		47	60				ns
t <sub>RFHRV</sub>	RFSH High to Row Address Valid	Figure 2		45	60				ns
tROHNC	RAS High to New Count Valid	Figure 2		30	55				ns
tRLEOC	RASIN Low to End-of-Count Low	C <sub>L</sub> = 50 pF, Figure 2			80				ns
tRHEOC	RASIN High to End-of-Count High	C <sub>L</sub> = 50pF, Figure 2			80				ns
t <sub>RST</sub>	Counter Reset Pulse Width	Figure 2	70						ns
t <sub>CTL</sub>	RF I/O Low to Counter Outputs All Low	Figure 2			100				ns
	TRI-STATE Parameter								7
t <sub>ZH</sub>	CS Low to Address Output High from Hi-Z	Figures 9, 12 R1 = 3.5k, R2 = 1.5k		35	60				ns.
t <sub>HZ</sub>	CS High to Address Output Hi-Z from High	C <sub>L</sub> = 15 pF, Figures 9, 12 R2 = 1 k, S1 open		20	40				ns
t <sub>ZL</sub>	CS Low to Address Output Low from Hi-Z	Figures 9, 12 R1 = 3.5k, R2 = 1.5k		35	60				ns
t <sub>LZ</sub>	CS High to Address Output Hi-Z from Low	$C_L = 15 pF$ , Figures 9, 12 R1 = 1k, S2 open		25	50				ns
t <sub>HZH</sub>	CS Low to Control Output High from Hi-Z High	Figures 9, 12 R2 = $750\Omega$ , S1 open		50	80				ns
t <sub>HHZ</sub>	CS High to Control Output Hi-Z High from High	$C_L = 15 pF,$ Figures 9, 12 R2 = 750 $\Omega$ , S1 open		40	75				ns
t <sub>HZL</sub>	CS Low to Control Output Low from Hi-Z High	Figure 12, S1, S2 open		45	75				ns
t <sub>LHZ</sub>	CS High to Control Output Hi-Z High from Low	$C_L = 15 pF$ , Figure 12, $R2 = 750\Omega$ , S1 open		50	80				ns

Symbol	Parameter	Conditions	Min	Тур	Max	Units
C <sub>IN</sub>	Input Capacitance ADS, R/C			8		pF
C <sub>IN</sub>	Input Capacitance All Other Inputs			5		pF

Note 1: "Absolute Maximum Ratings" are the values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: All typical values are for  $T_A = 25^{\circ}C$  and  $V_{CC} = 5.0V$ .

Note 3: This test is provided as a monitor of Driver output source and sink current capability. Caution should be exercised in testing this parameter. In testing these parameters, a 15Ω resistor should be placed in series with each output under test. One output should be tested at a time and test time should not exceed 1 second.

Note 4: Input pulse 0V to 3.0V,  $t_R = t_F = 2.5 \,\text{ns}$ ,  $f = 2.5 \,\text{MHz}$ ,  $t_{PW} = 200 \,\text{ns}$ . Input reference point on AC measurements is 1.5V. Output reference points are 2.7V for High and 0.8V for Low.

Note 5: The load capacitance on RF I/O should not exceed 50 pF.

Note 6: Applies to all DP8408 versions unless otherwise specified.

Note 7: The DP8408-2 device can only be used with memory devices that meet the  $t_{\mathsf{RAH}}$  specification indicated.

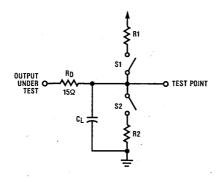


FIGURE 7. Output Load Circuit

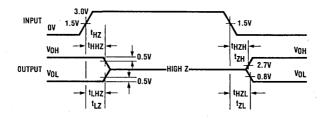


FIGURE 8. Waveform

#### **Applications**

If external control is preferred, the DP8408 may be used in Modes 0 or 4, as in Figure 3.

If basic auto access and refresh are required, then in cases where the user requires the minimum of external complexity, Modes 0 and 5 are ideal, as shown in Figure 9a. The DP843X2 is used to provide proper arbitration between memory access and refresh. This chip supplies all the necessary control signals to the processor as well as

the DP8408. Furthermore, two separate  $\overline{\text{CAS}}$  outputs are also included for systems using byte-writing. The refresh clock RFCK may be divided down from either RGCK using an IC counter such as the DM74LS393 or better still, the DP84300 Programmable Refresh Timer. The DP84300 can provide RFCK periods ranging from 15.4 $\mu$ s to 15.6 $\mu$ s based on the input clock of 2 to 10 MHz. Figure 9b shows the general timing diagram for interfacing the DP8408 to different microprocessors using the interface controller DP843X2.

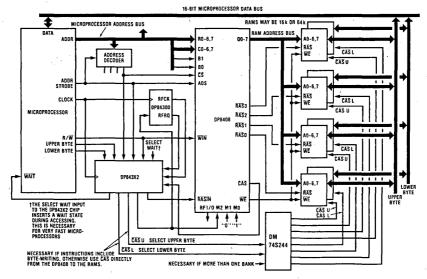


FIGURE 9a. Connecting the DP8408 Between the 16-Bit Microprocessor and Memory

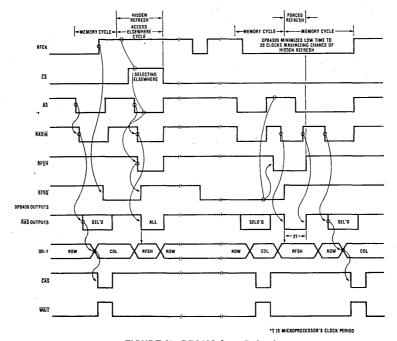


FIGURE 9b. DP8408 Auto Refresh

## **Dynamic Memory Support**

## DP8409 Multi-Mode Dynamic RAM Controller/Driver

#### **General Description**

Dynamic memory system designs, which formerly required several support chips to drive the memory array, can now be implemented with a single IC...the DP8409 Multi-Mode Dynamic RAM Controller/Driver. The DP8409 is capable of driving all 16k and 64k Dynamic RAMs (DRAMs) as well as 256k DRAMs. Since the DP8409 is a one-chip solution (including capacitive-load drivers), it minimizes propagation delay skews, the major performance disadvantage of multiple-chip memory drive and control.

The DP8409's 8 modes of operation offer a wide selection of DRAM control capabilities. Memory access may be controlled externally or on-chip automatically; an on-chip refresh counter makes refreshing (either externally or automatically controlled) less complicated; and automatic memory initialization is both simple and fast.

The DP8409 is a 48-pin DRAM Controller/Driver with 9 multiplexed address outputs and 6 control signals. It consists of two 9-bit address latches, a 9-bit refresh counter, and control logic. All output drivers are capable of driving 500 pF loads with propagation delays of 25 ns. The DP8409 timing parameters are specified driving the typical load capacitance of 88 DRAMs, including trace capacitance.

The DP8409 has 3 mode-control pins: M2, M1, and M0, where M2 is in general  $\overline{\text{REFRESH}}$ . These 3 pins select 8 modes of operation. Inputs B1 and B0 in the memory access modes (M2 = 1), are select inputs which select one of four  $\overline{\text{RAS}}$  outputs. During normal access, the 9 address outputs can be selected from the Row Address Latch or the Column Address Latch. During refresh, the 9-bit on-chip refresh counter is enabled onto the address bus and in this mode all  $\overline{\text{RAS}}$  outputs are selected, while  $\overline{\text{CAS}}$  is inhibited.

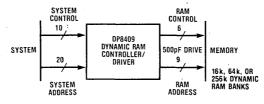
The DP8409 can drive up to 4 banks of DRAMs, with each bank comprised of 16k's, 64k's, or 256k's. Control signal outputs RAS, CAS, and WE are provided with the same drive capability. Each RAS output drives one bank of DRAMs so that the four RAS outputs are used to select the banks, while CAS, WE, and the multiplexed addresses can be connected to all of the banks of DRAMs. This leaves the non-selected banks in the standby mode (less than one tenth of the operating power) with the data outputs in TRI-STATE®. Only the bank with its associated RAS low will be written to or read from.

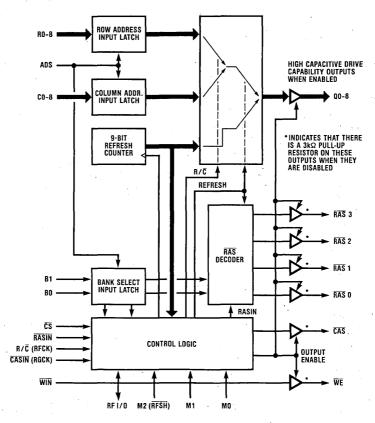
#### **Operational Features**

- All DRAM drive functions on one chip minimizes skew on outputs, maximizes AC performance
- On-chip capacitive-load drives (specified to drive up to 88 DRAMs)
- Drives directly all 16k, 64k, and 256k DRAMs
- Capable of addressing 64k, 256k, or 1M words
- Propagation delays of 25 ns typical at 500 pF load
- CAS goes low automatically after column addresses are valid if desired
- Auto Access mode provides RAS, row to column select, then CAS automatically and fast
- WE follows WIN unconditionally—offering READ, WRITE or READ-MODIFY-WRITE cycles
- On-chip 9-bit refresh counter with selectable End-of-Count (127, 255, or 511)
- End-of-Count indicated by RF I/O pin going low at 127, 255, or 511
- Low input on RF I/O resets 9-bit refresh counter
- CAS inhibited during refresh cycle
- Fall-through latches on address inputs controlled by ADS
- TRI-STATE outputs allow multi-controller addressing of memory
- Control output signals go high-impedance logic "1" when disabled for memory sharing
- Power-up: counter reset, control signals high, address outputs TRI-STATE, and End-of-Count set to 127

#### Mode Features

- 8 modes of operation: 3 access, 3 refresh, and 2 set-up
- 2 externally controlled modes: 1 access and 1 refresh (Modes 0, 4)
- 2 auto-access modes RAS → R/C → CAS automatic, with t<sub>RAH</sub> = 20 or 30ns minimum (Modes 5, 6)
- Auto-access mode allows Hidden Refreshing (Mode 5)
- Forced Refresh requested on RF I/O if no Hidden Refresh (Mode 5)
- Forced Refresh performed after system acknowledge of request (Mode 1)
- Automatic Burst Refresh mode stops at End-of-Count of 127, 255, or 511 (Mode 2)
- 2 All-RAS Access modes externally or automatically controlled for memory initialization (Modes 3a, 3b)
- Automatic All-RAS mode with external 8-bit counter frees system for other set-up routines (Mode 3a)
- End-of-Count value of Refresh Counter set by B1 and B0 (Mode 7)

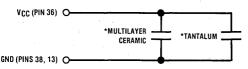




**DP8409 Functional Block Diagram** 

#### **Pin Definitions**

 $V_{CC}$ , GND, GND —  $V_{CC}$  = 5V ± 5%. The three supply pins have been assigned to the center of the package to reduce voltage drops, both DC and AC. There are also two ground pins to reduce the low level noise. The second ground pin is located two pins from  $V_{CC}$ , so that decoupling capacitors can be inserted directly next to these pins. It is important to adequately decouple this device, due to the high switching currents that will occur when all 9 address bits change in the same direction simultaneously. A recommended solution would be a  $1\mu F$  multilayer ceramic capacitor in parallel with a low-voltage tantalum capacitor, both connected as close as possible to pins 36 and 38 to reduce lead inductance. See Figure below.



\*Capacitor values should be chosen depending on the particular application.

R0-R8: Row Address Inputs.

C0-C8: Column Address Inputs.

Q0-Q8: Multiplexed Address Outputs — Selected from the Row Address Input Latch, the Column Address Input Latch, or the Refresh Counter.\*

RASIN: Row Address Strobe Input — Enables selected RAS<sub>n</sub> output when M2 (RFSH) is high, or all RAS<sub>n</sub> outputs when RFSH is low.

**RIC** (RFCK) — In Auto-Refresh Mode this pin is the external Refresh Clock Input: one refresh cycle has to be performed each clock period. In all other modes it is Row/Column Select Input: selects either the row or column address input latch onto the output bus.

CASIN (RGCK) — In Auto-Refresh Mode, Auto Burst Mode, and All-RAS Auto-Write Mode, this pin is the RAS Generator Clock input. In all other modes it is CASIN (Column Address Strobe Input), which inhibits CAS output when high in Modes 4 and 3b. In Mode 6 it can be used to prolong CAS output.

ADS: Address (Latch) Strobe Input — Row Address, Column Address, and Bank Select Latches are fall-through with ADS high; Latches on high-to-low transition.

CS: Chip Select Input — TRI-STATE's the Address Outputs and puts the control signal into a high-impedance logic "1" state when high (unless refreshing in one of the Refresh Modes). Enables all outputs when low.

M0, M1, M2: Mode Control Inputs — These 3 control pins determine the 8 major modes of operation of the DP8409 as depicted in Table 1.

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Table 1		Mada	Salact	Options
Table 1.	DF0403	MICUG	SOIDCE	Options

Mode	(RFSH) M2	M1	Мо	Mode of Operation	Conditions
0%	0	0	0	Externally Controlled Refresh	RF I/O = EOC
1	0	0	1	Auto Refresh — forced	RF I/O = Refresh Request (RFRQ)
2	0	1	0	Internal Auto Burst Refresh	RF I/O = EOC
3a	• 0	1	1	All RAS Auto Write	RF I/O = EOC; All RAS Active
3b	0	1	1 ,	Externally Controlled All RAS Access	All RAS Active
4	1	0	0	Externally Controlled Access	Active RAS defined by Table 2
5	1	0	1	Auto Access, Slow t <sub>RAH</sub> , Hidden Refresh	Active RAS defined by Table 2
6	1	1	0.	Auto Access, Fast t <sub>RAH</sub>	Active RAS defined by Table 2
7	1	1	1	Set End of Count	See Table 3 for Mode 7

RF I/O — The I/O pin functions as a Reset Counter Input when set low from an external open-collector gate, or as a flag output. The flag goes active-low in Modes 0 and 2 when the End-of-Count output is at 127, 255, or 511 (see Table 3), in Auto-Refresh Mode it is the Refresh Request output.

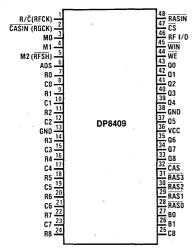
WIN: Write Enable Input.

WE: Write Enable Output — Buffered output from WIN.\*

CAS: Column Address Strobe Output — In Modes 3a, 5, and 6, CAS transitions low following valid column address. In Modes 3b and 4, it goes low after R/C goes low, or follows CASIN going low if R/C is already low. CAS is high during refresh.\*

RAS 0-3: Row Address Strobe Outputs - Selects a memory bank decoded from B1 and B0 (see Table 2), if RFSH is high. If RFSH is low, all banks are selected.\*

B0, B1: Bank Select Inputs — Strobed by ADS. Decoded to enable one of the RAS outputs when RASIN goes low. Also used to define End-of-Count in Mode 7 (Table 3).



Order Number DP8409N, DP8409N-2, DP8409N-3, DP8409D, DP8409D-2, DP8409D-3 See NS package N48A or D48A

Pin Configuration

#### Conditions for all Modes

#### Input Addressing

The address block consists of a row-address latch, a column-address latch, and a resettable refresh counter. The address latches are fall-through when ADS is high and latch when ADS goes low. If the address bus contains valid addresses until after the valid address time, ADS can be permanently high. Otherwise ADS must go low while the addresses are still valid.

In normal memory access operation, RASIN and R/C are initially high. When the address inputs are enabled into the address latches, the row addresses appear on the Q outputs. The address strobe also inputs the bank-select address, (B0 and B1). If CS is low, all outputs are enabled. When CS is transitioned high, the address outputs go TRI-STATE and the control outputs first go high through a low impedance, and then are held by an onchip high impedance. This allows output paralleling with other DP8409s for multi-addressing. All outputs go active about 50 ns after the chip is selected again. If CS is high, and a refresh cycle begins, all the outputs become active until the end of the refresh cycle.

#### **Drive Capability**

The DP8409 has timing parameters that are specified with up to 600 pF loads. In a typical memory system this is equivalent to about 88, 5V-only DRAMs, with trace lengths kept to a minimum. Therefore, the chip can drive four banks each of 16 or 22 bits, or two banks of 32 or 39 bits, or one bank of 64 or 72 bits.

Less loading will slightly reduce the timing parameters. and more loading will increase the timing parameters, according to the graph of Figure 10. The AC performance parameters are specified with the typical load capacitance of 88 DRAMs. This graph can be used to extrapolate the variations expected with other loading.

Because of distributed trace capacitance and inductance and DRAM input capacitance, current spikes can be created, causing overshoots and undershoots at the DRAM inputs that can change the contents of the DRAMs or even destroy them. To remove these spikes, a damping resistor (low inductance, carbon) can be inserted between the DP8409 driver outputs and the DRAMs, as close as possible to the DP8409. The values of the damping resistors may differ between the different control outputs;  $\overline{RAS}$ 's,  $\overline{CAS}$ , Q's, and  $\overline{WE}$ . The damping resistors should be determined by the first prototypes (not wire-wrapped due to the larger distributed capacitance and inductance). The best values for the damping resistors are the critical values giving a critically damped transition on the control outputs. Typical values for the damping resistors will be between 15 $\Omega$  and 100 $\Omega$ , the lower the loading the higher the value. (For more information, see AN-305 "Precautions to Take When Driving Memories.")

#### DP8409 Driving any 16k or 64k DRAMs

The DP8409 can drive any 16k or 64k DRAMs. All 16k DRAMs are basically the same configuration, including the newer 5V-only version. Hence, in most applications, different manufacturers' DRAMs are interchangeable

(for the same supply-rail chips), and the DP8409 can drive all 16k DRAMs (see Figure 1a).

There are three basic configurations for the 5V-only 64k DRAMs: a 128-row by 512-column array with an on-RAM refresh counter, a 128-row by 512-column array with no on-RAM refresh counter, and a 256-row by 256-column array with no on-RAM refresh counter. The DP8409 can drive all three configurations, and at the same time allows them all to be interchangeable (as shown in Figures 1b and 1c), providing maximum flexibility in the choice of DRAMs. Since the 9-bit on-chip refresh counter can be used as a 7-bit refresh counter for the 128-row configuration, or as an 8-bit refresh counter for the 256-row configuration, the on-RAM refresh counter (if present) is never used. As long as 128 rows are refreshed every 2 ms (i.e. 256 rows in 4 ms) all DRAM types are correctly refreshed.

#### DP8409 Interface Between System & DRAM Banks

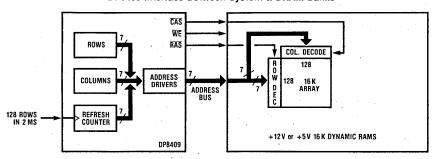
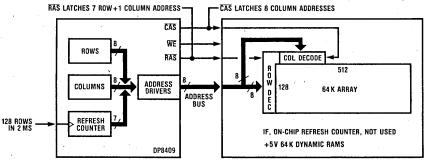


FIGURE 1a. DP8409 with any 16k DRAMS



ONLY LS 7 BITS OF REFRESH COUNTER USED FOR THE 7 ROW ADDRESSES. MSB NOT USED BUT CAN TOGGLE

#### FIGURE 1b. DP8409 with 128 Row × 512 Column 64k DRAM

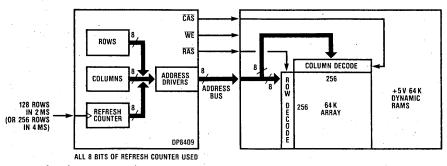


FIGURE 1c. DP8409 with 256 x 256 Column 64k DRAM

When the DP8409 is in a refresh mode, the RF I/O pin indicates that the on-chip refresh counter has reached its end-of-count. This end-of-count is selectable as 127, 255 or 512 to accommodate 16k, 64k, or 256k DRAMs. Although the end-of-count may be chosen to be any of these, the counter always counts to 511 before rolling over to zero.

## Read, Write, and Read-Modify-Write Cycles

The output signal,  $\overline{WE}$ , determines what type of memory access cycle the memory will perform. If  $\overline{WE}$  is kept high while  $\overline{CAS}$  goes low, a read cycle occurs. If  $\overline{WE}$  goes low before  $\overline{CAS}$  goes low, a write cycle occurs and data at DI (DRAM input data) is written into the DRAM as  $\overline{CAS}$  goes low. If  $\overline{WE}$  goes low later than  $t_{CWD}$  after  $\overline{CAS}$  goes low, first a read occurs and DO (DRAM output data) becomes valid; then data DI is written into the same address in the DRAM when  $\overline{WE}$  goes low. In this readmodify-write case, DI and DO cannot be linked together. The type of cycle is therefore controlled by  $\overline{WE}$ , which follows  $\overline{WIN}$ .

## Power-Up Initialize

When  $V_{CC}$  is first applied to the DP8409, an initialize pulse clears the refresh counter, the internal control flip-flops, and sets the End-of-Count of the refresh counter to 127 (which may be changed via Mode 7). As  $V_{CC}$  increases to about 2.3 volts, it holds the output control signals at a level of one Schottky diode-drop below  $V_{CC}$ , and the output address to TRI-STATE. As  $V_{CC}$  increases above 2.3 volts, control of these outputs is granted to the system.

# DP8409 Functional Mode Descriptions

Note: All delay parameters stated in text refer to the DP8409. Substitute the respective delay numbers for the DP8409-2 or DP8409-3 when using these devices

## Mode 0 — Externally Controlled Refresh

Figure 2 is the Externally Controlled Refresh Timing. In this mode, the input address latches are disabled from the address outputs and the refresh counter is enabled. When  $\overline{\text{RAS}}$  occurs, the enabled row in the DRAM is refreshed. In the Externally Controlled Refresh mode, all  $\overline{\text{RAS}}$  outputs are enabled following  $\overline{\text{RASIN}}$ , and  $\overline{\text{CAS}}$  is inhibited. This refreshes the same row in all four banks. The refresh counter increments when either  $\overline{\text{RASIN}}$  or  $\overline{\text{RFSH}}$  goes low-to-high after a refresh. RF I/O goes low when the count is 127, 255, or 511, as set by End-of-Count (see Table 3), with  $\overline{\text{RASIN}}$  and  $\overline{\text{RFSH}}$  low. To reset the counter to all zeroes, RF I/O is set low through an external open-collector driver.

During refresh,  $\overline{\text{RASIN}}$  and RFSH must be skewed transitioning low such that the refresh address is valid on the address outputs of the controller before the  $\overline{\text{RAS}}$  outputs go low. The amount of time that RFSH should go low before  $\overline{\text{RASIN}}$  does depends on the capacitive loading of the address and  $\overline{\text{RAS}}$  lines. For the load specified in the switching characteristics of this data sheet, 10ns is sufficient. Refer to Figure 2.

To perform externally controlled burst refresh, RASIN is toggled while RFSH is held low. The refresh counter increments with RASIN going low to high, so that the DRAM rows are refreshed in succession by RASIN going high to low.

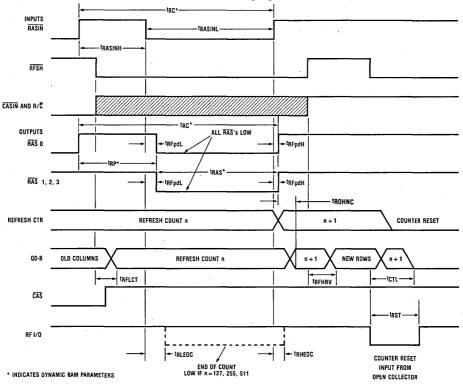


FIGURE 2. External Control Refresh Cycle (Mode 0)

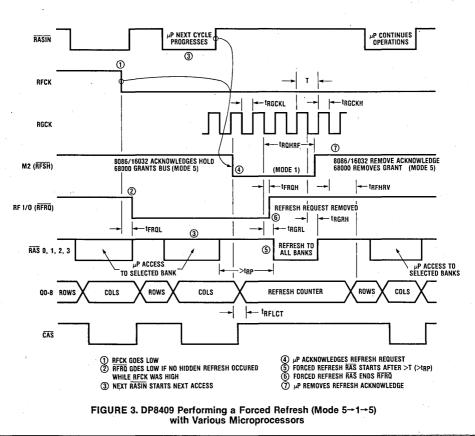
### Mode 1 — Automatic Forced Refresh

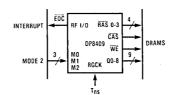
In Mode 1, the R/C (RFCK) pin becomes RFCK (refresh cycle clock), instead of R/C, and CAS remains high. If RFCK is kept permanently high, then whenever M2 (RFSH) goes low, an externally controlled refresh will occur and all RAS outputs will follow RASIN, strobing the refresh counter contents to the DRAMs. The RF I/O pin will always output high, but when set low externally through an open-collector driver, the refresh counter resets as normal. This externally controlled method may be preferred when operating in the Automatic Access mode (Mode 5), where hidden or forced refreshing is undesirable, but refreshing is still necessary.

If RFCK is an input clock signal, one (and only one) refresh cycle must take place every RFCK cycle. Refer to Figure 9. If a hidden refresh does not occur while RFCK is high, in Mode 5, then RF 1/O (Refresh Request) goes low immediately after RFCK goes low, indicating to the system that a forced refresh is requested. The system must allow a forced refresh to take place while RFCK is low (refer to Figure 3). The Refresh Request signal on RF I/O may be connected to a Hold or Bus Request input to the system. The system acknowledges the Hold or Bus Request when ready, and outputs Hold Acknowledge or Bus Request Acknowledge. If this is connected to the M2 (RFSH) pin, a forced-refresh cycle will be initiated by the DP8409, and RAS will be internally generated on all four RAS outputs, to strobe the refresh counter contents on the address outputs into all the DRAMs. An external RAS Generator Clock

(RGCK) is required for this function. It is fed to the CASIN (RGCK) pin, and may be up to 10 MHz. Whenever M2 goes low (inducing a forced refresh), RAS remains high for one to two periods of RGCK, depending on when M2 goes low relative to the high-to-low triggering edge of RGCK; RAS then goes low for two periods, performing a refresh on all banks. In order to obtain the minimum delay from M2 going low to RAS going low, M2 should go low t<sub>RFSRG</sub> before the next falling edge of RGCK. The Refresh Request on RF I/O is terminated as RAS begins, so that by the time the system has acknowledged the removal of the request and disabled its Acknowledge, (i.e., M2 goes high), Refresh RAS will have ended, and normal operations can begin again in the Automatic Access mode (Mode 5). If it is desired that Refresh RAS end in less than 2 periods of RGCK from the time RAS went low, then M2 may be high earlier than t<sub>BOHBE</sub> after RGCK goes low and RAS will go high t<sub>BERH</sub> after M2, if CS is low. If CS is high, the RAS will go high impedance high after 25ns after M2 goes high.

To allow the forced refresh, the system will have been inactive for about 4 periods of RGCK, which can be as fast as 400ns every RFCK cycle. To guarantee a refresh of 128 rows every 2 ms, a period of up to 16  $\mu s$  is required for RFCK. In other words, the system may be down for as little as 400ns every 16  $\mu s$ , or 2.5% of the time. Although this is not excessive, it may be preferable to perform a Hidden Refresh each RFCK cycle, which is allowed while still in the Auto-Access mode, (Mode 5).





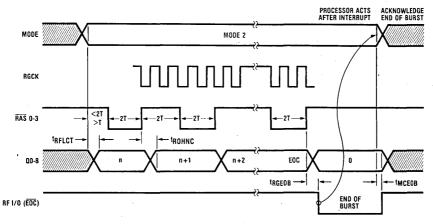


FIGURE 4. Auto-Burst Mode, Mode 2

#### Mode 2 — Automatic Burst Refresh

This mode is normally used before and/or after a DMA operation to ensure that all rows remain refreshed, provided the DMA transfer takes less than 2 ms (see Figure 4). When the DP8409 enters this mode, CASIN (RGCK) becomes the RAS Generator Clock (RGCK), and RASIN is disabled. CAS remains high, and RF I/O goes low when the refresh counter has reached the selected End-of-Count and the last RAS has ended. RF I/O then remains low until the Auto-Burst Refresh mode is terminated. RF I/O can therefore be used as an interrupt to indicate the End-of-Burst condition.

The signal on all four  $\overline{AAS}$  outputs is just a divide-by-four of RGCK; in other words, if RGCK has a 100 ns period,  $\overline{AAS}$  is high and low for 200 ns each cycle. The refresh counter increments at the end of each  $\overline{AAS}$ , starting from the count it contained when the mode was entered. If this was zero, then for a RGCK with a 100 ns period with End-of Count set to 127, RF I/O will go low after  $128 \times 0.4 \,\mu s$ , or  $51.2 \,\mu s$ . During this time, the system may be performing operations that do not involve DRAM. If all rows need to be burst refreshed, the refresh counter may be cleared by setting RF I/O low externally before the burst begins.

Burst-mode refreshing is also useful when powering down systems for long periods of time, but with data retention still required while the DRAMs are in standby. To maintain valid refreshing, power can be applied to the DP8409 (set to Mode 2), causing it to perform a complete burst refresh. When end-of-burst occurs (after 26  $\mu$ s), power can then be removed from the DP8409 for 2 ms, consuming an average power of 1.3% of normal operating power. No control signal glitches occur when switching power to the DP8409.

## Mode 3a - All-RAS Automatic Write

Mode 3a is useful at system initialization, when the memory is being cleared (i.e., with all-zeroes in the data field and the corresponding check bits for error detection and correction). This requires writing the same data to each location of memory (every row of each column of each bank). All  $\overline{\text{RAS}}$  outputs are activated, as in refresh, and so are  $\overline{\text{CAS}}$  and  $\overline{\text{WE}}$ . To write to all four banks simultaneously, every row is strobed in each column, in sequence, until data has been written to all locations.

To select this mode, B1 and B0 must have previously been set to 00, 01, or 10 in Mode 7, depending on the DRAM size. For example, for 16k DRAMs, B1 and B0 are 00. For 64k DRAMs, B1 and B0 are 01, so that for the configuration of Figure 1b, the 8 refresh counter bits are strobed by RAS into the 7 row addresses and the ninth column address. After this Automatic-Write process, B1 and B0 must be set again in Mode 7 to 00 to set End-of-Count to 127. For the configuration of Figure 1c, B1 and B0 set to 01 will work for Automatic-Write and End-of-Count equals 255.

In this mode,  $R/\overline{C}$  is disabled;  $\overline{WE}$  is permanently enabled low, and  $\overline{CASIN}$  (RGCK) becomes RGCK. RF I/O goes low whenever the refresh counter is 127, 255, or 511 (as set by End-of-Count in Mode 7), and the  $\overline{RAS}$  outputs are active.

Referring to Figure 5a, an external 8-bit counter (for 64k DRAMs) with TRI-STATE outputs is required and must be connected to the column address inputs. It is enabled only during this mode, and is clocked from RF I/O. The DP8409 refresh counter is used to address the rows, and the column address is supplied by the external counter. Every row for each column address is written to in all four banks. At the End-of-Count RF I/O goes low, which clocks the external counter.

Therefore, for each column address, the refresh counter first outputs row-0 to the address bus and all four RAS outputs strobe this row address into the DRAMs (see Figure 5b). A minimum of 30ns after RAS goes low (t<sub>RAH</sub> = 30 ns), the refresh counter is disabled and the column address input latch is enabled onto the address bus. About 14 ns after the column address is valid, CAS goes low, (t<sub>ASC</sub> = +14ns), strobing the column address into the DRAMs. When RAS and CAS go high the refresh counter increments to the next row and the cycle repeats. Since WE is kept low in this mode, the data at DI (input data) of the DRAMs is written into each row of the latched column. During each cycle RAS is high for two periods of RGCK and low for two periods, giving a total write-cycle time of 400 ns minimum, which is adequate for most 16k and 64k DRAMs. On the last row of a column, RF I/O increments the external counter to the next column address. At the end of the last column address, an interrupt is generated from the external counter to let the system know that initialization has been completed. During the entire initialization time, the system can be performing other initialization functions. This approach to memory initialization is both automatic and fast. For instance, if four banks of 64k DRAMs are used, and RGCK is 100 ns, a write cycle to the same location in all four banks takes 400 ns, so the total time taken in initializing the 64k DRAMs is 65k  $\times$  400 ns or 26 ms. When the system receives the interrupt, the external counter must be permanently disabled. ADS and  $\overline{\rm CS}$  are interfaced by the system, and the DP8409 mode is changed. The interrupt must then be disabled.

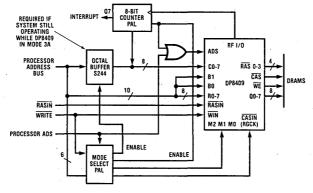


FIGURE 5a. DP8409 Extra Circuitry Required for All-RAS Auto Write Mode, Mode 3a

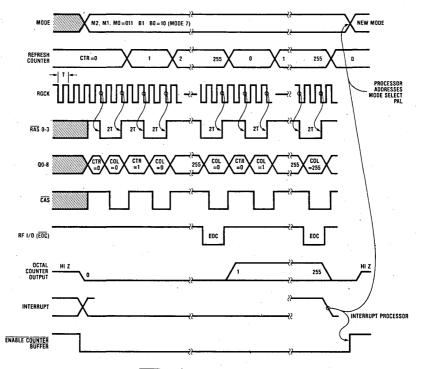


FIGURE 5b. DP8409 All-RAS Auto Write Mode, Mode 3a, Timing Waveform

To select this mode, B1 and B0 must first have been set to 11 in Mode 7. This mode is useful at system initialization, but under processor control. The memory address is provided by the processor, which also performs the incrementing. All four RAS outputs follow RASIN (supplied by the processor), strobing the row address into the DRAMs. RIC can now go low, while CASIN may be used to control CAS (as in the Externally Controlled Access mode), so that CAS strobes the column address contents into the DRAMs. At this time WE should be low, causing the data to be written into all four banks of DRAMs. At the end of the write cycle, the input address is incremented and latched by the DP8409 for the next write cycle. This method is slower than Mode 3a since the processor must perform the incrementing and accessing. Thus the processor is occupied during RAM initialization, and is not free for other initialization operations. However, initialization sequence timing is under system control, which may provide some system advantage.

## Mode 4 — Externally Controlled Access

This mode facilitates externally controlling all accesstiming parameters associated with the DRAMs. The application of modes 0 and 4 are shown in Figure 6.

#### **Output Address Selection**

Refer to Figure 7a. With M2 (RFSH) and R/C high, the row address latch contents are transferred to the multiplexed address bus output Q0-Q8, provided CS is set low. The column address latch contents are output after R/C goes low. RASIN can go low after the row addresses have been set up on Q0-Q8. This selects one of the RAS outputs, strobing the row address on the Q outputs into the desired bank of memory. After the row-address hold-time of the DRAMs, R/C can go low so that about 40 ns later column addresses appear on the Q outputs.

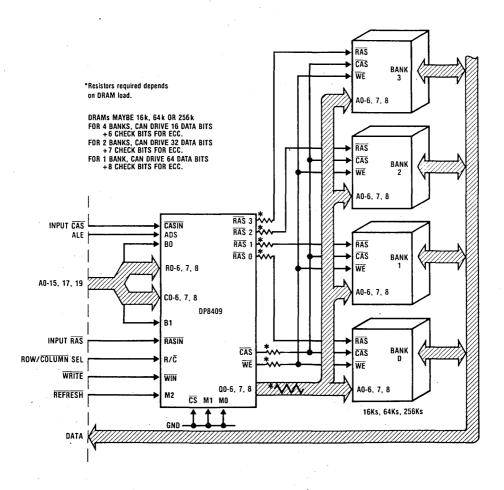


FIGURE 6. Typical Application of DP8409 Using External Control Access and Refresh in Modes 0 and 4

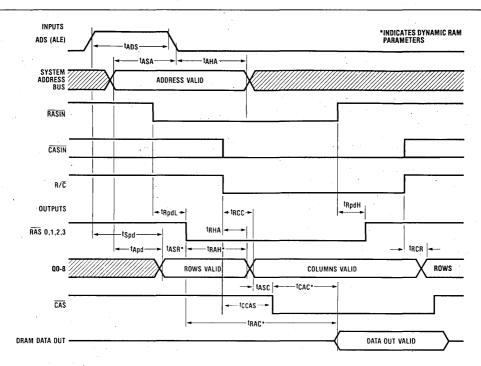


FIGURE 7a. Read Cycle Timing (MODE 4)

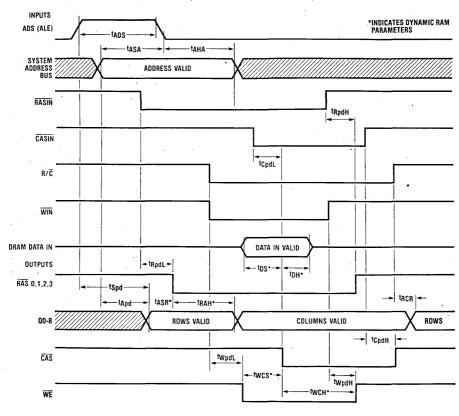


FIGURE 7b. Write Cycle Timing (Mode 4)

In a normal memory access cycle CAS can be derived from inputs CASIN or R/C. If CASIN is high, then R/C going low switches the address output drivers from rows to columns. CASIN then going low causes CAS to go low approximately 40 ns later, allowing CAS to occur at a predictable time (see Figure 7b). If CASIN is low when R/C goes low, CAS will be automatically generated, following the row to column transition by about 20 ns (see Figure 7a). Most DRAMs have a column address set-up time before  $\overline{CAS}$  (t<sub>ASC</sub>) of 0 ns or - 10 ns. In other words, a t<sub>ASC</sub> greater than 0 ns is safe.

## **Fast Memory Access**

AC parameters t<sub>DIF1</sub>, t<sub>DIF2</sub> may be used to determine the minimum delays required between RASIN, R/C, and CASIN (see Application Brief 9; "Fastest DRAM Access Mode").

## Mode 5 — Automatic Access with Hidden Refresh

The Auto Access with Hidden Refresh mode has two advantages over the Externally Controlled Access mode, due to the fact that all outputs except WE are initiated from RASIN. First, inputs R/C and CASIN are unnecessary and can be used for other functions (see Refreshing, below). Secondly, because the output control signals are derived internally from one input signal (RASIN), timing-skew problems are reduced, thereby reducing memory access time substantially or allowing use of slower DRAMs. The automatic access features of Mode 5 (and Mode 6) of the DP8409 make DRAM accessing appear essentially "static".

#### **Automatic Access Control**

The major disadvantage of DRAMs compared to static RAMs is the complex timing involved. First, a RAS must occur with the row address previously set up on the multiplexed address bus. After the row address has been held for t<sub>RAH</sub>, (the Row-Address hold-time of the DRAM), the column address is set up and then CAS occurs. This is all performed automatically by the DP8409 in this mode.

Provided the input address is valid as ADS goes low, RASIN can go low any time after ADS. This is because the selected RAS occurs typically 27 ns later, by which time the row address is already valid on the address output of the DP8409. The Address Set-Up time (t<sub>ASR</sub>), is Ons on most DRAMs. The DP8409 in this mode (with ADS and RASIN edges simultaneously applied) produces a minimum t<sub>ASR</sub> of Ons. This is true provided the input address was valid t<sub>ASA</sub> before ADS went low (see Figure 8a).

Next, the row address is disabled after t<sub>RAH</sub> (30ns minimum); in most DRAMs, t<sub>RAH</sub> minimum is less than 30 ns. The column address is then set up and tasc later, CAS occurs. The only other control input required is WIN. When a write cycle is required, WIN must go low at least 30 ns before CAS is output low.

This gives a total typical delay from: input address valid to RASIN (15 ns); to RAS (27 ns); to rows held (50 ns); to columns valid (25ns); to CAS (23ns) = 140ns (that is, 125 ns from RASIN). All of these typical figures are for heavy capacitive loading, of approximately 88 DRAMs.

This mode is therefore extremely fast. The external timing is greatly simplified for the memory system designer: the only system signal required is RASIN.

### Refreshing

Because R/C and CASIN are not used in this mode, R/C becomes RFCK (refresh clock) and CASIN becomes RGCK (RAS generator clock). With these two signals it is possible to perform refreshing without extra ICs, and without holding up the processor.

One refresh cycle must occur during each refresh clock period and then the refresh address must be incremented to the next refresh cycle. As long as 128 rows are refreshed every 2ms (one row every 16 µs), all 16k and 64k DRAMs will be correctly refreshed. The cycle time of RFCK must, therefore, be less than 16 µs. RFCK going high sets an internal refresh-request flip-flop. First the DP8409 will attempt to perform a hidden refresh so that the system throughput will not be affected. If, during the time RFCK is high, CS on the DP8409 goes high and RASIN occurs, a hidden refresh will occur. In this case, RASIN should be considered a common read/write strobe. In other words, if the processor is accessing elsewhere (other than the DRAMs) while RFCK is high, the DP8409 will perform a refresh. The refresh counter is enabled to the address outputs whenever CS goes high with RFCK high, and all RAS outputs follow RASIN. If a hidden refresh is taking place as RFCK goes low, the refresh continues. At the start of the hidden refresh, the refreshrequest flip-flop is reset so no further refresh can occur until the next RFCK period starts with the positive-going edge of RFCK. Refer to Figure 9.

To determine the probability of a Hidden Refresh occurring, assume each system cycle takes 400 ns and RFCK is high for 8 µs, then the system has 20 chances to not select the DP8409. If during this time a hidden refresh did not occur, then the DP8409 forces a refresh while RFCK is low, but the system chooses when the refresh takes place. After RFCK goes low, (and the internalrequest flip-flop has not been reset), RF I/O goes low indicating that a refresh is requested to the system. Only when the system acknowledges this request by setting M2 (RFSH) low does the DP8409 initiate a forced refresh (which is performed automatically). Refer to Mode 1, and Figure 3. The internal refresh request flipflop is then reset.

Figure 9 illustrates the refresh alternatives in Mode 5. If a hidden refresh has occurred and CS again goes high before RFCK goes low, the chip is deselected. All the control signals go high-impedance high (logic "1") and the address outputs go TRI-STATE until CS again goes low. This mode (combined with Mode 1) allows very fast access, and automatic refreshing (possibly not even slowing down the system), with no extra ICs. Careful system design can, and should, provide a higher probability of hidden refresh occurring. The duty cycle of RFCK need not be 50-percent; in fact, the low-time should be designed to be a minimum. This is determined by the worst-case time (required by the system) to respond to the DP8409's forced-refresh request.

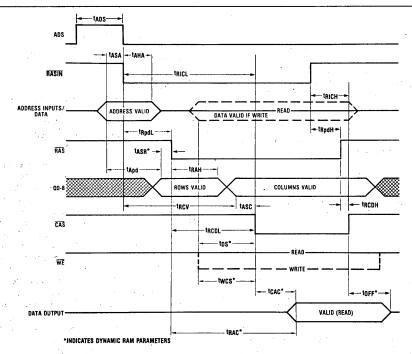


FIGURE 8a. Modes 5, 6 Timing (CASIN High in Mode 6)

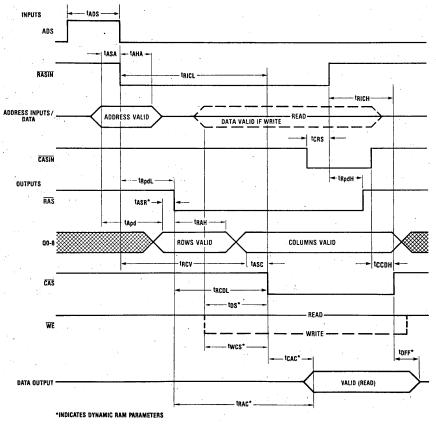
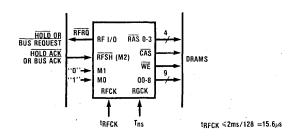


FIGURE 8b. Mode 6 Timing, Extended CAS



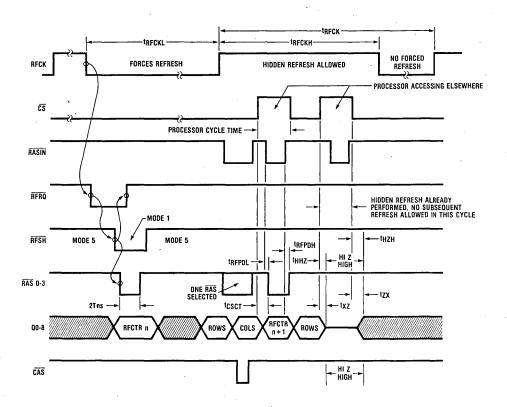


FIGURE 9. Hidden Refreshing (Mode 5) and Forced Refreshing (Mode 1) Timing

Table 2. Memory Bank Decode

Bank ( (Strobed		Fachlad DAC
B1	В0	Enabled RAS <sub>n</sub>
0	0	RAS <sub>0</sub>
0	1	RAS <sub>1</sub>
1	. 0	RAS <sub>2</sub>
1 .	1	RAS₃

Note that  $\overline{\text{RASIN}}$  going low earlier than  $t_{\text{CSRL}}$  after  $\overline{\text{CS}}$  goes low may result in the DP8409 interpreting the  $\overline{\text{RASIN}}$  as a hidden refresh  $\overline{\text{RASIN}}$  if no hidden refresh has occurred in the current RFCK cycle. In this case, all  $\overline{\text{RAS}}$  outputs would go low for a short time. Thus, it is suggested that when using Mode 5,  $\overline{\text{RASIN}}$  should be held high until  $t_{\text{CSRL}}$  after  $\overline{\text{CS}}$  goes low if a refresh is not intended. Similarly,  $\overline{\text{CS}}$  should be held low for a minimum of  $t_{\text{CSRL}}$  after  $\overline{\text{RASIN}}$  returns high when ending the access in Mode 5.

#### Mode 6 — Fast Automatic Access

The Fast Access mode is similar to Mode 5, but has a faster t<sub>RAH</sub> of 20ns, minimum. It therefore can only be used with fast 16k or 64k DRAMs (which have a t<sub>RAH</sub> of 10ns to 15ns) in applications requiring fast access times; RASIN to CAS is typically 105ns.

In this mode, the R/C (RFCK) pin is not used, but CASIN (RGCK) is used as CASIN to allow an extended CAS after RAS has already terminated. Refer to Figure 8b. This is desirable with fast cycle-times where RAS has to be terminated as soon as possible before the next RAS

begins (to meet the precharge time, or t<sub>RP</sub>, requirements of the DRAM). CAS may then be held low by CASIN to extend the data output valid time from the DRAM to allow the system to read the data. CASIN subsequently going high ends CAS. If this extended CAS is not required, CASIN should be set high in Mode 6.

There is no internal refresh-request flip-flop in this mode, so any refreshing required must be done by entering Mode 0 or Mode 2.

## Mode 7 - Set End-of-Count

The End-of-Count can be externally selected in Mode 7, using ADS to strobe in the respective value of B1 and B0 (see Table 3). With B1 and B0 the same  $\overline{EOC}$  is 127; with B1 = 0 and B0 = 1,  $\overline{EOC}$  is 255; and with B1 = 1 and B0 = 0,  $\overline{EOC}$  is 511. This selected value of  $\overline{EOC}$  will be used until the next Mode 7 selection. At power-up the  $\overline{EOC}$  is automatically set to 127 (B1 and B0 set to 11).

Table 3. Mode 7

	Select by ADS)	End of Count
B1 .	B0	Selected
0	0	127
0	. 1	255
' 1	. 0	511
1	1	. 127

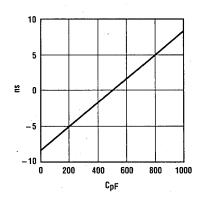


FIGURE 10. Change in Propagation Delay vs. Loading Capacitance Relative to a 500pF Load

## **Absolute Maximum Ratings** (Note 1)

\*Derate cavity package 23.6mW/°C above 25°C; derate molded

package 22.7mW/°C above 25°C.

Supply Voltage, V<sub>CC</sub> 7.0V
Storage Temperature Range -65°C to +150°C
Input Voltage 5.5V
Output Current 150 mA
Lead Temperature (Soldering, 10 seconds) 300°C

Maximum Power Dissipation\* at 25°C Cavity Package Molded Package

3542mW 2833mW

## **Operating Conditions**

	Min	Max	Units
V <sub>CC</sub> Supply Voltage	4.75	5.25	٧
T <sub>A</sub> Ambient Temperature	0	+70	°C

Electrical Characteristics V<sub>CC</sub> = 5.0V ± 5%, 0°C ≤ T<sub>A</sub> ≤ 70°C unless otherwise noted (Notes 2, 6)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>C</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min., I <sub>C</sub> = −12 mA	1	-0.8	-1.2	V
I <sub>IH1</sub>	Input High Current for ADS, R/C only	V <sub>IN</sub> = 2.5V		2.0	100	μА
I <sub>IH2</sub>	Input High Current for All Other Inputs*	V <sub>IN</sub> = 2.5V		1.0	50	μΑ
I <sub>I</sub> RSI	Output Load Current for RF I/O	V <sub>IN</sub> = 0.5V, Output High		-1.5	-2.5	mA
I <sub>I</sub> CTL	Output Load Current for RAS, CAS, WE	V <sub>IN</sub> = 0.5V, Chip Deselect		-1.5	-2.5	mA
I <sub>IL1</sub>	Input Low Current for ADS, R/C only	V <sub>IN</sub> = 0.5V		-0.1	-1.0	mA
I <sub>IL2</sub>	Input Low Current for All Other Inputs*	V <sub>IN</sub> = 0.5V		-0.05	-0.5	mA
V <sub>IL</sub>	Input Low Threshold				0.8	V
V <sub>IH</sub>	Input High Threshold		2.0			V
V <sub>OL1</sub>	Output Low Voltage*	I <sub>OL</sub> = 20 mA		0.3	0.5	V
V <sub>OL2</sub>	Output Low Voltage for RF I/O	I <sub>OL</sub> = 10 mA		0.3	0.5	V
V <sub>OH1</sub>	Output High Voltage*	I <sub>OH</sub> = -1 mA	2.4	3.5		٧
V <sub>OH2</sub>	Output High Voltage for RF I/O	$I_{OH} = -100\mu A$	2.4	3.5		V
I <sub>1D</sub>	Output High Drive Current*	V <sub>OUT</sub> = 0.8V (Note 3)		-200		mA
I <sub>OD</sub>	Output Low Drive Current*	V <sub>OUT</sub> = 2.7V (Note 3)		200		mA
loz	TRI-STATE Output Current (Address Outputs)	0.4V ≤ V <sub>OUT</sub> ≤ 2.7V, <del>CS</del> = 2.0V, Mode 4	-50	1.0	50	μΑ
Icc	Supply Current	V <sub>CC</sub> = Max.		250	325	mA

<sup>\*</sup>Except RF I/O Output.

Switching Characteristics: DP8409/DP8409-3  $V_{CC} = 5.0V \pm 5\%$ ,  $0^{\circ}C \leqslant T_{A} \leqslant 70^{\circ}C$  unless otherwise noted (Notes 2, 4, 5). The output load capacitance is typical for 4 banks of 22 DRAMs each or 88 DRAMs including trace capacitance. These values are: Q0-Q8,  $C_L = 500\,pF$ ; RAS0-RAS3,  $C_L = 150\,pF$ ; WE,  $C_L = 500\,pF$ ; CAS,  $C_L = 600\,pF$ , unless otherwise noted. See Figure 11 for test load. Switches S1 and S2 are closed unless otherwise noted, and R1 and R2 are  $4.7k\Omega$  unless otherwise noted. Maximum propagation delays are specified with all outputs switching.

	Access Parameter			8409		8			
Symbol	Access Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
t <sub>RICL</sub>	RASIN to CAS Output Delay (Mode 5)	Figure 8a	95	125	160	95	125	185	ns
t <sub>RICL</sub>	RASIN to CAS Output Delay (Mode 6)	Figures 8a, 8b	80	105	140	80	105	160	ns
tRICH	RASIN to CAS Output Delay (Mode 5)	Figure 8a	40	48	60	40	. 48	70	ns
t <sub>RICH</sub>	RASIN to CAS Output Delay (Mode 6)	Figures 8a, 8b	50	63	80	50	63	95	ns
tRCDL	RAS to CAS Output Delay (Mode 5)	Figure 8a		98	125		98	145	ns
t <sub>RCDL</sub>	RAS to CAS Output Delay (Mode 6)	Figures 8a, 8b		78	105		78	120	ns
t <sub>RCDH</sub>	RAS to CAS Output Delay (Mode 5)	Figure 8a		27	40		27	40	ns
tRCDH	RAS to CAS Output Delay (Mode 6)	Figure 8a		40	65		. 40	65	ns
tccdh	CASIN to CAS Output Delay (Mode 6)	Figure 8b	40	54	70	40	54	80	ns
t <sub>RAH</sub>	Row Address Hold Time (Mode 5)	Figure 8a	30			30			ns
t <sub>RAH</sub>	Row Address Hold Time (Mode 6)	Figures 8a, 8b	20			20			ns
t <sub>ASC</sub>	Column Address Setup Time (Mode 5)	Figure 8a	8			8			ns
t <sub>ASC</sub>	Column Address Setup Time (Mode 6)	Figures 8a, 8b	6			6			ns
t <sub>RCV</sub>	RASIN to Column Address Valid (Mode 5)	Figure 8a		90	120		90	140	ns

t<sub>EROL</sub>

#### Switching Characteristics (Cont'd) 8409 8409 - 3Symbol Access Parameter Conditions Units Min Тур Max Min Тур Max RASIN to Column Address Valid (Mode 6) Figures 8a, 8b 75 105 75 tRCV 120 ns RASIN to RAS Delay 35 **TRPDL** Figures 7a, 7b, 8a, 8b 20 27 20 27 40 ns RASIN to RAS Delay Figures 7a, 7b, 8a, 8b 15 15 23 37 **TRPDH** 23 32 ns 25 TAPDL Address Input to Output Low Delay Figures 7a, 7b, 8a, 8b 25 40 46 ns Address Input to Output High Delay 25 40 25 46 **TAPDH** Figures 7a, 7b, 8a, 8b ns Address Strobe to Address Output Low Figures 7a, 7b 40 60 40 70 t<sub>SPDL</sub> ns Address Strobe to Address Output High Figures 7a, 7b 40 70 t<sub>SPDH</sub> 40 60 ns t<sub>ASA</sub> Address Set-up Time to ADS Figures 7a, 7b, 8a, 8b 15 15 ns Address Hold Time from ADS Figures 7a, 7b, 8a, 8b 15 15 TAHA ns Address Strobe Pulse Width Figures 7a, 7b, 8a, 8b 30 30 t<sub>ADS</sub> ns WIN to WE Output Delay Figure 7b 15 25 30 15 25 35 t<sub>WPDL</sub> ns WIN to WE Output Delay Figure 7b 15 30 60 15 30 70 **twpph** ns CASIN Set-up Time to RASIN High (Mode 6) Figure 8b 35 35 tcrs ns CASIN to CAS Delay (R/C low in Mode 4) Figure 7b 32 41 68 32 41 77 t<sub>CPDL</sub> ns CASIN to CAS Delay (R/C low in Mode 4) t<sub>CPDH</sub> Figure 7b 25 39 50 25 39 60 ns Column Select to Column Address Valid t<sub>RCC</sub> Figure 7a 40 58 40 67 ns Row Select to Row Address Valid 40 40 t<sub>RCR</sub> Figures 7a, 7b 58 67 ns Row Address Held from Column Select Figure 7a 10 10 t<sub>RHA</sub> ns R/C Low to CAS Low (Mode 4 Auto CAS) 65 90 Figure 7a t<sub>CCAS</sub> ns t<sub>DIF1</sub> Maximum (t<sub>RPDI</sub> - t<sub>RHA</sub>) See Mode 4 13 18 ns description See Mode 4 13 t<sub>DIF2</sub> Maximum (t<sub>BCC</sub> - t<sub>CPDL</sub>) 18 ns description Refresh Parameter Refresh Cycle Period Figure 2 100 100 tRC ns Pulse Width of RASIN during Refresh Figure 2 50 50 ns tRASINL. RASIN to RAS Delay during Refresh Figures 2. 9 35 50 70 35 50 80 t<sub>REPDL</sub> ns RASIN to RAS Delay during Refresh Figures 2, 9 30 40 55 30 40 65 **t**RFPDH ns 47 RFSH Low to Counter Address Valid $\overline{CS} = X$ , Figures 2,3,4 60 47 70 **t**RFLCT ns RFSH High to Row Address Valid 45 60 45 70 **t**RFHRV Figures 2, 3 ns RAS High to New Count Valid Figures 2, 4 30 55 30 55 **t**ROHNC ns RASIN Low to End-of-Count Low C<sub>L</sub> = 50 pF, Figure 2 80 80 ns **t**RLEOC RASIN High to End-of-Count High $C_1 = 50 pF$ , Figure 2 80 80 ns **t**RHEOC RGCK Low to End-of-Burst Low C<sub>L</sub> = 50 pF, Figure 4 95 95 **t**RGEOB ns 75 Mode Change to End-of-Burst High $C_1 = 50 pF$ , Figure 4 75 **t**MCFOR ns Counter Reset Pulse Width Figure 2 70 70 **t<sub>RST</sub>** ns RF I/O Low to Counter Outputs All Low 100 100 Figure 2 t<sub>CTL</sub> ns Minimum Pulse Width of RFCK Figure 9 100 100 t<sub>RFCKL</sub>H ns Period of RAS Generator Clock Figure 3 100 100 ns Figure 3 Minimum Pulse Width Low of RGCK 35 40 ns **t**RGCKL **t**RGCKH Minimum Pulse Width High of RGCK Figure 3 35 40 ns RFCK Low to Forced RFRQ Low 20 20

 $C_1 = 50 pF$ , Figure 3

30

30

## Switching Characteristics (Cont'd)

	Policach Parameter	0	8409			8	J., ,,		
Symbol	Refresh Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
t <sub>FROH</sub>	RGCK Low to Forced RFRQ High	$C_L = 50 pF$ , Figure 3		50	75		50	75	ns
t <sub>RGRL</sub>	RGCK Low to RAS Low	Figure 3	. 50	65	95	50	65	95	ns
t <sub>RGRH</sub>	RGCK Low to RAS High	Figure 3	40	60	85	40	60	85	ns
t <sub>RQHRF</sub>	RFSH Hold Time from RFSH RQST (RF I/O)	Figure 3	2T			2T			ns
t <sub>RFRH</sub>	RFSH High to RAS High (ending forced RFSH)	See Mode 1 Descrip.	55	80	110	55	80	125	ns
t <sub>RFSRG</sub>	RFSH Low Set-up to RGCK Low (Mode 1)	See Mode 1 Descrip.	35			40			ns
t <sub>CSCT</sub>	CS High to RFSH Counter Valid	Figure 9		55	70		55	75	ns
t <sub>CSRL</sub>	CS Low to Access RASIN Low	See Mode 5 Descrip.	10			15		1	ns

## TRI-STATE Parameter

t <sub>ZH</sub>	CS Low to Address Output High from Hi-Z	Figures 9, 12 R1 = 3.5k, R2 = 1.5k	35	60	 35	60	ns
t <sub>HZ</sub>	CS High to Address Output Hi-Z from High	C <sub>L</sub> = 15 pF, Figures 9, 12 R2 = 1k, S1 open	20	40	20	40	ns
t <sub>ZL</sub>	CS Low to Address Output Low from Hi-Z	Figures 9, 12 R1 = 3.5k, R2 = 1.5k	35	60	35	60	ns
t <sub>LZ</sub>	CS High to Address Output Hi-Z from Low	C <sub>L</sub> = 15 pF, Figures 9, 12, R1 = 1k, S2 open	25	50	25	50	ns
t <sub>HZH</sub>	CS Low to Control Output High from Hi-Z High	Figures 9, 12 R2 = 750Ω, S1 open	50	80	50	80	ns
t <sub>HHZ</sub>	CS High to Control Output Hi-Z High from High	C <sub>L</sub> = 15 pF, Figures 9, 12 R2 = 750Ω, S1 open	40	75	40	75	ns
t <sub>HZL</sub>	CS Low to Control Output Low from Hi-Z High	Figure 12, S1, S2 open	45	75	45	75	ns
t <sub>LHZ</sub>	CS High to Control Output Hi-Z High from Low	$C_L = 15  \text{pF},$ Figure 12, R2 = 750 $\Omega$ , S1 open	50	80	50	80	ns

**Switching Characteristics:** DP8409-2  $V_{CC} = 5.0V \pm 5\%$ ,  $0^{\circ}C \leqslant T_{A} \leqslant 70^{\circ}C$  unless otherwise noted (Notes 2, 4, 5). The output load capacitance is typical for 4 banks of 22 DRAMs each or 88 DRAMs including trace capacitance. These values are: Q0-Q8,  $C_L = 500\,pF$ ;  $\overline{RAS0} = 78.50$ ,  $C_L = 150\,pF$ ;  $\overline{WE}$ ,  $C_L = 500\,pF$ ;  $\overline{CAS}$ ,  $C_L = 600\,pF$ , unless otherwise noted. See Figure 11 for test load. Switches S1 and S2 are closed unless otherwise noted, and R1 and R2 are  $4.7k\Omega$  unless otherwise noted. Maximum propagation delays are specified with all outputs switching.

	Access Barameter	0	8409 – 2						
Symbol	Access Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
t <sub>RICL</sub>	RASIN to CAS Output Delay (Mode 5)	Figure 8a	75	100	130				ns
tRICL	RASIN to CAS Output Delay (Mode 6)	Figures 8a, 8b	65	.90	115				ns
tRICH	RASIN to CAS Output Delay (Mode 5)	Figure 8a	40	48	60				ns
tRICH	RASIN to CAS Output Delay (Mode 6)	Figures 8a, 8b	50	63	80				ns
t <sub>RCDL</sub>	RAS to CAS Output Delay (Mode 5)	Figure 8a		75	100				ns
tRCDL	RAS to CAS Output Delay (Mode 6)	Figures 8a, 8b		65	85				ns
tRCDH	RAS to CAS Output Delay (Mode 5)	Figure 8a		27	40				ns
t <sub>RCDH</sub>	RAS to CAS Output Delay (Mode 6)	Figure 8a		40	65		2.00		ns
tccph	CASIN to CAS Output Delay (Mode 6)	Figure 8b	40	54	70				ns
t <sub>RAH</sub>	Row Address Hold Time (Mode 5) (Note 7)	Figure 8a	20						ns

# Switching Characteristics (Cont'd)

Cumb-1	Access Barameter	Conditions	8	<u> 409 – </u>	2				;
Symbol	Access Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Uı
t <sub>RAH</sub>	Row Address Hold Time (Mode 6) (Note 7)	Figures 8a, 8b	12						n
ASC	Column Address Setup Time (Mode 5)	Figure 8a	3						n
ASC	Column Address Setup Time (Mode 6)	Figures 8a, 8b	3		<u> </u>		<u> </u>		n
t <sub>RCV</sub>	RASIN to Column Address Valid (Mode 5)	Figure 8a		80	105			<u> </u>	r
t <sub>RCV</sub>	RASIN to Column Address Valid (Mode 6)	Figures 8a, 8b		70	90			<u> </u>	r
t <sub>RPDL</sub>	RASIN to RAS Delay	Figures 7a, 7b, 8a, 8b	20	27	35				r
t <sub>RPDH</sub>	RASIN to RAS Delay	Figures 7a, 7b, 8a, 8b	15	23	32				r
t <sub>apdl</sub>	Address Input to Output Low Delay	Figures 7a, 7b, 8a, 8b		25	40				r
t <sub>APDH</sub>	Address Input to Output High Delay	Figures 7a, 7b, 8a, 8b		25	40				r
tSPDL	Address Strobe to Address Output Low	Figures 7a, 7b		40	60				r
t <sub>SPDH</sub>	Address Strobe to Address Output High	Figures 7a, 7b		40	60				r
tASA	Address Set-up Time to ADS	Figures 7a, 7b, 8a, 8b	15						r
t <sub>AHA</sub>	Address Hold Time from ADS	Figures 7a, 7b, 8a, 8b	.15						r
t <sub>ADS</sub>	Address Strobe Pulse Width	Figures 7a, 7b, 8a, 8b	30	_					r
twppl	WIN to WE Output Delay	Figure 7b	15	25	30				r
twpph	WIN to WE Output Delay	Figure 7b	15	30	60	-			r
t <sub>CRS</sub>	CASIN Set-up Time to RASIN High (Mode 6)	Figure 8b	35						r
t <sub>CPDL</sub>	CASIN to CAS Delay (R/C low in Mode 4)	Figure 7b	32	41	58				r
t <sub>CPDH</sub>	CASIN to CAS Delay (R/C low in Mode 4)	Figure 7b	25	39	50			1	r
t <sub>RCC</sub>	Column Select to Column Address Valid	Figure 7a	-	40	58				r
t <sub>RCR</sub>	Row Select to Row Address Valid	Figures 7a, 7b		40	58				r
t <sub>RHA</sub>	Row Address Held from Column Select	Figure 7a	10			!			г
t <sub>CCAS</sub>	R/C Low to CAS Low (Mode 4 Auto CAS)	Figure 7a		55	75				,
t <sub>DIF1</sub>	Maximum (t <sub>RPDL</sub> – t <sub>RHA</sub> )	See Mode 4 description			13				r
t <sub>DIF2</sub>	Maximum (t <sub>RCC</sub> – t <sub>CPDL</sub> )	See Mode 4 description			13				ı
		:			•				•
t <sub>RC</sub>	Refresh Parameter Refresh Cycle Period	Figure 2	100	<del>                                     </del>	Γ	T ·	Ι	T -	T 1
t <sub>RASINL</sub> H		Figure 2	50			<del>                                     </del>	<del> </del>	<del> </del> -	'
t <sub>RFPDL</sub>	RASIN to RAS Delay during Refresh	Figures 2, 9	35	50	70	<del> </del>	<del> </del>	<del> </del>	
	RASIN to RAS Delay during Refresh	Figures 2, 9	30	40	55	├	<del> </del>		+
t <sub>RFPDH</sub>	RFSH Low to Counter Address Valid	<del>CS</del> = X, Figures 2,3,4		47	60	+	<u> </u>		-
TRFLCT	RFSH High to Row Address Valid	Figures 2, 3	-	45	60	<del>                                     </del>	<del> </del>	<del>                                     </del>	┼╌
t <sub>RFHRV</sub>	RAS High to New Count Valid	Figures 2, 4		30	55	<del> </del>		<del> </del>	L.
t <sub>ROHNC</sub>	<u></u>	<del> </del>	ļ.—	30	<del> </del>	<del> </del>	-	1.	
t <sub>RLEOC</sub>	RASIN Low to End-of-Count Low	$C_L = 50 \text{ pF}$ , Figure 2		-	80		<del> </del>	+	-
TRHEOC	RASIN High to End-of-Count High	$C_L = 50 \text{ pF}$ , Figure 2	-		80	-	┼		-
<sup>t</sup> RGEOB	RGCK Low to End-of-Burst Low	C <sub>L</sub> = 50 pF, Figure 4	<u> </u>		95	<del> </del>	<u> </u>	<del> </del>	-
<sup>†</sup> мсеов	Mode Change to End-of-Burst High	C <sub>L</sub> = 50 pF, Figure 4			75	-	-		'
trst	Counter Reset Pulse Width	Figure 2	70	ļ	ļ		<u> </u>		_ '
t <sub>CTL</sub>	RF I/O Low to Counter Outputs All Low	Figure 2			100		1	1	

ns

ns

ns

ns

			8	409 –	2				
Symbol	Access Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
t <sub>RFCKL,H</sub>	Minimum Pulse Width of RFCK	Figure 9	100						ns
T	Period of RAS Generator Clock	Figure 3	100						ns
t <sub>RGCKL</sub>	Minimum Pulse Width Low of RGCK	Figure 3	35						ns
tRGCKH	Minimum Pulse Width High of RGCK	Figure 3	35						ns
tFRQL	RFCK Low to Forced RFRQ Low	$C_L = 50 pF$ , Figure 3		20	30				ns
t <sub>FRQH</sub>	RGCK Low to Forced RFRQ High	C <sub>L</sub> = 50 pF, Figure 3		50	75				ns
t <sub>RGRL</sub>	RGCK Low to RAS Low	Figure 3	50	65	95				ns
t <sub>RGRH</sub>	RGCK Low to RAS High	Figure 3	40	60	85				ns
tROHRE	RFSH Hold Time from RFSH RQST (RF I/O)	Figure 3	2T						ns
t <sub>RFRH</sub>	RFSH High to RAS High (ending forced RFSH)	See Mode 1 Descrip.	55	80	110				ns
t <sub>RFSRG</sub>	RFSH Low Set-up to RGCK Low (Mode 1)	See Mode 1 Descrip.	35						ns
t <sub>CSCT</sub>	CS High to RFSH Counter Valid	Figure 9		55	70	_			ns
t <sub>CSRL</sub>	CS Low to Access RASIN Low	See Mode 5 Descrip.	10						ns
t <sub>ZH</sub>	CS Low to Address Output High from Hi-Z	Figures 9, 12 R1 = 3.5k, R2 = 1.5k		35	60				ns
t <sub>HZ</sub>	CS High to Address Output Hi-Z from High	$C_L = 15 pF$ , Figures 9, 12 R2 = 1k, S1 open		20	40				ns
t <sub>ZL</sub>	CS Low to Address Output Low from Hi-Z	Figures 9, 12 R1 = 3.5k, R2 = 1.5k		35	60				ns
t <sub>LZ</sub>	CS High to Address Output Hi-Z from Low	C <sub>L</sub> = 15pF, Figures 9, 12 R1 = 1k, S2 open		25	50		-		ns
								<del></del>	_

Figures 9, 12

Figures 9, 12

 $C_L = 15 pF$ .

Figure 12,

Figure 12,

S1, S2 open  $C_L = 15 pF$ ,

 $R2 = 750\Omega$ , S1 open

 $R2 = 750\Omega$ , S1 open

 $R2 = 750\Omega$ , S1 open

50 80

40

45

50

75

75

80

Input Capacitance T<sub>A</sub> = 25°C (Notes 2, 6)

CS Low to Control Output High from

CS High to Control Output Hi-Z High

CS Low to Control Output Low from

CS High to Control Output Hi-Z High

tHZH

t<sub>HHZ</sub>

**t**HZL

tLHZ

Hi-Z High

from High

Hi-Z High

from Low

Symbol	Parameter	Conditions	Min	Тур	Max	Units
CIN	Input Capacitance ADS, R/C		,	8		pF
C <sub>IN</sub>	Input Capacitance All Other Inputs			5		pF

Note 1: "Absolute Maximum Ratings" are the values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: All typical values are for  $T_A = 25$ °C and  $V_{CC} = 5.0$ V.

Note 3: This test is provided as a monitor of Driver output source and sink current capability. Caution should be exercised in testing this parameter. In testing these parameters, a 15Ω resistor should be placed in series with each output under test. One output should be tested at a time and test time should not exceed 1 second.

Note 4: Input pulse 0V to 3.0V,  $t_B = t_F = 2.5 \, \text{ns}$ ,  $f = 2.5 \, \text{MHz}$ ,  $t_{PW} = 200 \, \text{ns}$ . Input reference point on AC measurements is 1.5V. Output reference points are 2.7V for High and 0.8V for Low.

Note 5: The load capacitance on RF I/O should not exceed 50 pF.

Note 6: Applies to all DP8409 versions unless otherwise specified.

Note 7: The DP8409-2 device can only be used with memory devices that meet the t<sub>RAH</sub> specification indicated.

## **Applications**

If external control is preferred, the DP8409 may be used in Mode 0 or 4, as in Figure 6.

If basic auto access and refresh are required, then in cases where the user requires the minimum of external complexity, Modes 1 and 5 are ideal, as shown in Figure 13a. The DP843X2 is used to provide proper arbitration between memory access and refresh. This chip supplies all the necessary control signals to the processor as well as the DP8409. Furthermore, two separate CAS outputs are also included for systems using byte-writing. The refresh clock RFCK may be divided down from either RGCK using an IC counter such as the DM74LS393 or better still, the DP84300 Programmable Refresh Timer. The DP84300 can provide RFCK periods ranging from 15.4 µs to 15.6 µs based on the input clock of 2 to 10 MHz. Figure 13b shows the general timing diagram for interfacing the DP8409 to different microprocessors using the interface controller DP843X2.

FIGURE 11. Output Load Circuit

If the system is complex, requiring automatic access and refresh, burst refresh, and all-banks auto-write, then more circuitry is required to select the mode. This may be accomplished by utilizing a PAL. The PAL has two functions. One as an address comparator, so that when the desired port address occurs (programmed in the PAL), the comparator gates the data into a latch, where it is connected to the mode pins of the DP8409. Hence the mode of the DP8409 can be changed as desired with one PAL chip merely by addressing the PAL location, and then outputting data to the mode-control pins. In this manner, all the automatic modes may be selected, assigning R/C as RFCK always, and CASIN as RGCK always. The output from RF I/O may be used as End-of-Count to an interrupt, or Refresh Request to HOLD or BUS REQUEST. A complex system may use Modes 5 and 1 for automatic access and refresh, Modes 3a and 7 for system initialization, and Mode 2 (auto-burst refresh) before and after DMA.

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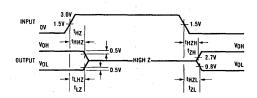


FIGURE 12. Waveform

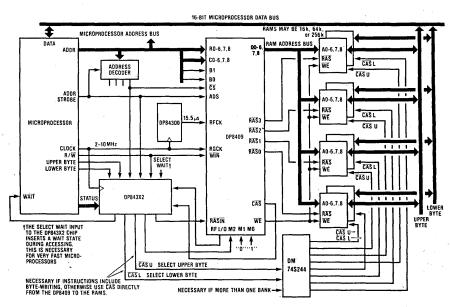


FIGURE 13a. Connecting the DP8409 Between the 16-bit Microprocessor and Memory

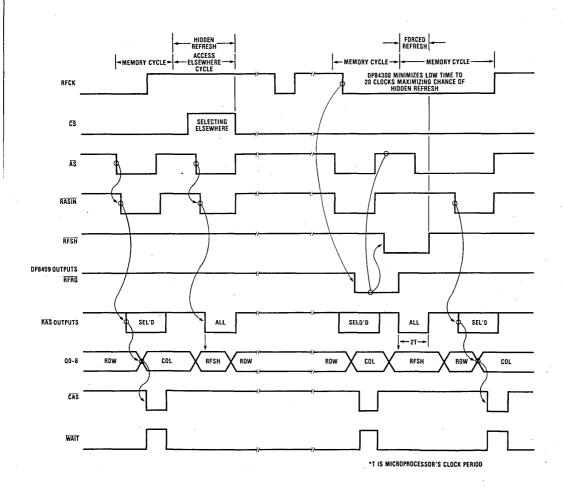


FIGURE 13b. DP8409 Auto Refresh



# Dynamic Memory Support PRELIMINARY

## **DP8419 High Speed Dynamic RAM Controller/Driver**

## **General Description**

The DP8419 High Speed DRAM Controller/Driver combines the most popular memory control features of the DP8408/9 DRAM Controller/Driver with the high speed of Bipolar Oxide Isolation processing.

The DP8419 retains the high capacitive-load drive capability of the DP8408/9 as well as its most frequently used access and refresh modes, allowing it to directly replace the DP8408/9 in applications using only modes 0, 1, 4 and 5. Thus, the DP8419 will allow most DP8408/9 users to directly upgrade their system simply by replacing their old controller chip with the DP8419.

Since only two of the three mode pins from the DP8408/9 are necessary to select the four available DP8419 modes, M1 of the DP8408/9 is called RAHS on the DP8419 and allows the user the option of selecting  $t_{\rm RAH}$  to suit his DRAMs.

Figure 1 shows the DP8419 pinout. It is identical to that of the DP8408/9, except for pin 4 which has become RAHS.

Table 1 is a DP8419 mode table. Pins 3 and 5 are used to select from the four available operational modes. Note that the mode selection scheme is identical to that of the DP8408/9 with M1 (pin 4) tied low.

## **Features**

- Pin and functionally compatible with the DP8408/9 DRAM Controllers in most applications
- Significantly faster memory access and refresh due to Bipolar Oxide Isolation processing
- Choice of t<sub>RAH</sub> is pin selectable
- Nibble mode accessing available in external control mode

## **Connection Diagram**

## **Dual-In-Line Package**

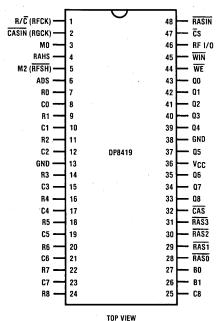


FIGURE 1.

Table 1. DP8419 Mode Select Options

Mode	(RFSH) M2	МО	Mode of Operation
0 .	0	0	Externally Controlled Refresh
1	-0	1	Auto Refresh — Forced
4	1	0	Externally Controlled Access
5	1	1	Auto Access (Hidden Refresh)

# **DP8408, DP8409 Application Hints**

National Semiconductor Application Brief #1 Tim Garverick June 1983



The DP8408, DP8409 dynamic RAM controllers have been well received by dynamic memory users because they perform functions formerly requiring multiple integrated circuit chips. These controllers are designed to be suitable for a variety of DRAM control methods. As a result of the many combinations of ways in which inputs to these chips may be varied, it was inevitable that certain conditions exist that would cause the DP8408, DP8409 to respond in an undesirable way. Feedback from customers using these chips has resulted in thorough investigations of such conditions. The following are constraints on the use of the DRAM controllers which are not addressed in their data sheets. The majority of customers will find that most of the items on this list are not pertinent to their particular application, and those that are impose minimal restrictions.

- The on-chip refresh counter resets when the RFI/O pin goes low for a refresh request in mode 5 if this pin is excessively loaded with capacitance. The data sheet suggests that this pin not be loaded with greater than 50 pF. Since RFI/O, in most cases, needs only to drive a low capacitance in a refresh control circuit, this limit is not unreasonable.
- 2) When the DP8408, DP8409 is in a refresh mode, the RFI/O pin indicates that the on-chip refresh counter has reached its end-of-count. This end-of-count is selectable as 127, 255 or 511 (511 is available only on the DP8409) to accommodate 16k, 64k or 256k DRAMs, respectively. Although the end-of-count may be chosen to be any of these, the counter always counts to 511 (255 for the DP8408) before rolling over to zero.
- 3) In mode 5, the DP8409 requests a refresh when RFI/O goes low following RFCK (R/C). DP8409s with date code 8209 or earlier, have a slight functional difference from later DP8409s. With CS = 1, RFI/O goes low for only about 10 ns when RFCK goes low, for early DP8409s. It stays high until mode 1 is entered and then responds as specified in the data sheet. DP8409s with date codes after 8209 function as shown in the data sheet with CS = 1. If CS = 0 all DP8409s operate as specified in the data sheet.
- 4) When going from mode 0, 1 or 2 (refresh) to mode 5 of the DP8408, if <u>CASIN</u> and R/C are both low, a glitch occurs on the <u>CAS</u> output. Since neither of these inputs is used in these modes, one or both should be held high.
- 5) Most DRAMs specify 0 ns row address set-up time to RAS. In order to guarantee this, the row address to the

- DP8408,DP8409 must be valid 10 ns before  $\overline{RASIN}$  transitions low to initiate an access. In terms of the data sheet parameters, maximum ( $t_{APD}$ - $t_{RPDL}$ ) = 10 ns.
- 6) When changing modes from refresh to access, again sufficient time must be allowed for the row address to be valid before RAS occurs. In this case, the address outputs of the DP8408, DP8409 are changing from the refresh counter to the row address inputs. In order for the row address to be set up a minimum of 0 ns before RAS goes low, RASIN should not go low until 30 ns after the change from refresh to access mode.
- 7) Both the low and high pulse widths of RAS have minimum requirements during refresh. When in mode 0, the RASIN to RAS low delay is longer than the RASIN to RAS high delay. In terms of the data sheet parameters, maximum (t<sub>RFPDL</sub> t<sub>RFPDH</sub>) = 25 ns. Thus, the minimum low pulse width of RAS in mode 0 equals the RASIN low pulse width minus 25 ns. The minimum high pulse width of RAS in mode 0 equals the RASIN high pulse width.
- The fastest memory access may be accomplished using mode 4 and external delay lines (see App. Brief #9).
- 9) In the data sheet, it is specified that CS should go low 15 ns (t<sub>CSLR</sub>) before RASIN goes low to initiate an access in mode 5. This is to prevent the possibility of a glitch on the RASIN as a hidden refresh. For the same reason, CS should be held low for a minimum of 15 ns after RASIN returns high, ending the access in mode 5.
- 10) If the DP8409 is being used in mode 5 and  $\overline{CS} = 1$ , and if  $\overline{RASIN}$  goes low within 15 ns before RFCK (R/ $\overline{C}$ ) goes low, up to a 15 ns glitch may occur on the refresh request pin, RFI/O. However, since  $\overline{CS}$  is high, a hidden refresh will occur as it normally would with RFCK high. If the glitch on RFI/O were detected and interpreted as a forced refresh request, no forced refresh would be allowed by the DP8409 since a hidden refresh was allowed. This would not cause any problem, however, since the hidden refresh has taken care of the refresh requirement for that period of RFCK. Also, this forced refresh request could not be detected if the system does not check RFI/O for a low state while  $\overline{RASIN}$  is low (i.e., an access is taking place).

# DP8408/9 Fastest DRAM Access Mode

National Semiconductor Application Brief # 9 Tim Garverick Rusty Meier February 1983



If one desires the fastest possible operation of the DP8408/9 multi-mode dynamic RAM controller/driver in accessing DRAMs, mode 4, externally controlled access mode should be considered.

In using mode 4 there are three input signals which must be considered:

- 1) RASIN generates RAS
- R/C switches between rows and columns on the address outputs
- 3) CASIN generates CAS

In producing these signals a delay will be needed between RASIN and R/C and between R/C and CASIN. (Note: In mode 4 external generation of CASIN can produce CAS faster than automatic generation of CAS.)

Two important parameters have been added to the DP8408/9 data sheets that help one compute the minimum acceptable delays between the above-mentioned signals. These parameters are:

- 1) t<sub>DIF1</sub> = MAXIMUM (t<sub>RPDL</sub> t<sub>RHA</sub>) = 13 ns where t<sub>RPDL</sub> = RASIN to RAS delay t<sub>RHA</sub> = row address held from column select
- 2)  $t_{DIF2} = MAXIMUM (t_{RCC} t_{CPDL}) = 13 \text{ ns}$ where  $t_{RCC} = \text{column select to column address}$ valid  $t_{CPDL} = \overline{CASIN} \text{ to } \overline{CAS} \text{ delay}$

These parameters are specified as being less than what would be calculated using the min/max values given for  $t_{RCC},\,t_{CPDL},\,t_{RPDL}$  and  $t_{RHA}$  in the DP8408/9 specification sheets, because on-chip delays track over temperature and supply variations.

The equation for the delay between  $\overline{\text{RASIN}}$  and  $R/\overline{C}$  that guarantees the specified DRAM  $t_{RAH}$  is:

min delay required =  $t_{DIF1} + t_{RAH}$ = 13 ns +  $t_{RAH}$ 

where  $t_{RAH} = DRAM$  minimum row address hold time from  $\overline{RAS}$ 

The equation for the delay between R/C and CASIN that guarantees the specified DRAM t<sub>ASC</sub> is:

min delay required =  $t_{DIF2} + t_{ASC}$ = 13 ns +  $t_{ASC}$ 

where

t<sub>ASC</sub> = DRAM minimum column address set-up time to CAS

To produce the above-mentioned delays between signals, a  $\pm 2$  ns resolution delay line can be used as follows:

(assuming  $t_{RAH} = 20$  ns,  $t_{ASC} = 0$  ns)  $\overline{RASIN}$  to  $R/\overline{C}$  delay = 13 ns + 20 ns = 33 ns

 $R/\overline{C}$  to  $\overline{CASIN}$  delay = 13 ns + 0 ns = 13 ns

Thus, R/ $\overline{C}$  must follow  $\overline{RASIN}$  by a minimum of 33 ns and  $\overline{CASIN}$  must follow R/ $\overline{C}$  by a minimum of 13 ns. With a delay line of  $\pm$  2 ns resolution, the  $\overline{RASIN}$  to R/ $\overline{C}$  and R/ $\overline{C}$  to  $\overline{CASIN}$  delays can be typicals of 35 ns and 15 ns, respectively. (See Figures 1 and 2 below.)

This scheme will provide a maximum  $\overline{\text{RASIN}}$  to  $\overline{\text{CAS}}$  delay of:

35 ns + 15 ns + 2 ns (resolution uncertainty) + MAXIMUM ( $t_{CPDL}$ ) = 52 ns + MAXIMUM ( $t_{CPDL}$ )

For the DP8408/9-2, MAXIMUM  $(t_{CPDL}) = 58$  ns.

For the DP8408/9 (no dash), MAXIMUM ( $t_{CPDL}$ ) = 68 ns (not 58 ns as indicated in data sheets up to November 1982).

The fastest mode 4 accesses (with the assumed delay line and DRAM parameters) are therefore, 110 ns and 120 ns, respectively, for the -2 and non-dash parts.

The maximum  $\overline{\text{RASIN}}$  to  $\overline{\text{CAS}}$  delay  $(t_{\text{RICL}})$  in mode 5 (auto mode) for the DP8408/9-2 (which guarantees a min  $t_{\text{RAH}}$  of 20 ns) is 130 ns. The maximum  $t_{\text{RICL}}$  in mode 5 for the DP8408/9 (no dash) is 160 ns.

Thus, it is shown that if the features offered by the DP8408/9 automatic modes can be sacrificed, mode 4 (externally controlled access) may be used to obtain the fastest memory access.

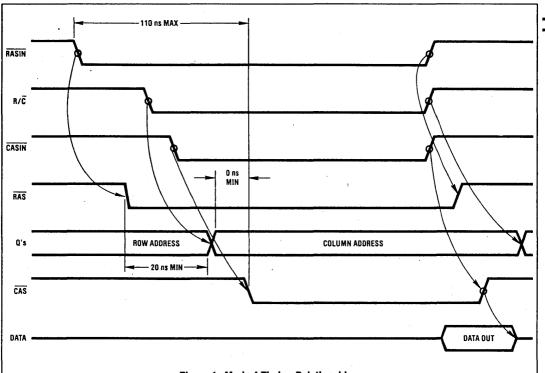


Figure 1. Mode 4 Timing Relationships

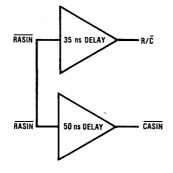


Figure 2. Mode 4 Externally Generated Signals

# **Precautions to Take When Driving Memories**

National Semiconductor Application Note AN-305 June 1982 Mike Evans



As memory prices continue their relentless reduction of cost per bit, more and more systems designers are incorporating memories into their designs. In general these memories comprise a number of dynamic RAMs, such as the  $64k \times 1$ . In this  $\times 1$  configuration, the number of RAMs required is a multiple of the bus width. Most new system designs use 16-bit microprocessors, so that a typical memory will comprise from 16 to 64 DRAMs, thus providing from 64k to 256k addressing capability. This means the memory drivers have to drive upwards of 16 RAMs. The drivers may be part of an integrated circuit dynamic RAM controller such as the DP8408/DP8409, or they may be on a separate chip such as the DP84240/DP84244 octal memory drivers. The recommendations in this article are valid for any type of memory driver. The purpose of the article is to forewarn new designers using memories of problems they will encounter if adequate precautions are not taken.

A typical configuraton of a 16-bit wide memory is shown in Figure 1. Each driver address output goes to every dynamic RAM, as does  $\overline{\rm WE}$ .  $\overline{\rm CAS}$  outputs go to half the number of RAMs assuming byte writing is required.  $\overline{\rm RAS}$  outputs each go only to one bank. Note that these loads are not true for the data inputs and outputs. Each data I/O only connects to its respective bit, so the loading is only one RAM per bank for data. In general, this is why buffers are not required on the data bus when interfacing to memory. Data In of the RAMs can be linked directly to Data Out for any one bit, and also to the corresponding bit on the data bus. This is true for normal read and write operations, but if read-modify-write cycles are employed, the Data Out signals must be buffered from the data bus.

Using this typical memory configuration may not be as simple as it seems. Without care and attention, problems can arise for the unprepared, and there are two areas in particular which may cause memory errors or memory damage: one is voltage overshoot caused by inductive traces and high capacitive loads, the other is switching spikes caused by switching high capacitive loads.

## Overshoot and Undershoot

(Undershoot is Negative Overshoot)

When a system requires a number of dynamic RAMs, the result is high capacitance loads, caused by a combination of RAM input capacitance and trace capacitance. Each dynamic RAM has a specified input capacitance of 10pF maximum, but most dynamic RAMs are closer to 2 to 3pF. Very few actually get close to 10pF, even under worst case conditions of high temperature and V<sub>CC</sub>. It is safe, therefore, to assume a much lower average input capacitance when using 16 or more RAMs.

In fact, the input capacitance of most inputs is due more to the package than the input gating, because the silicon gate inputs of the transistors in today's market have such high impedance. A typical maximum would be 2.5 pF. Control inputs such as RAS and CAS connect to more than one transistor input. For example, on the National Semiconductor 64k×1 dynamic RAM, the NMC4164. RAS goes to two transistors and CAS to four. In general, this is true for most manufacturers' RAMs, so a more typical maximum input capacitance would be 3pF for RAS and 3.5pF for CAS. RAM input currents are so small as to be negligible. The input current is quoted as 10µA maximum, but again most RAMs are much less than this in a typical memory. Driving DRAMs, therefore, is not a problem of DC drive capability, but rather a problem of capacitance drive capability.

Driving DRAM input capacitance is further compounded by printed circuit traces, and even more so by wire-wrapping. Both can be represented by a transmission line with distributed capacitance and inductance. Thus, the total load is equivalent to a complex impedance comprising the distributed trace inductance, and a capacitance comprising distributed trace capacitance and RAM input capacitance as shown in *Figure 2a*.

The effect is an overshoot or undershoot at the dynamic RAM inputs that occurs each time a memory driver changes state, as shown in Figure 2b. As the driver output changes state, the load capacitance cannot be instantaneously charged or discharged because the current available is limited both by the driver transistor impedance, and the equivalent series resistance from the supply rail through the chip to the trace resistance. This current will be similar in value to the quoted short circuit current of the driver stage; therefore, there is a spike of current that lasts as long as it takes to change the voltage of all the capacitances. For the driver stages of the DP8408/DP8409, or the DP84240/DP84244, the typical short circuit current is 100mA per stage. This is true for either direction, so that the high-to-low transition takes roughly the same time as the low-to-high transition, minimizing skew times on all the driver outputs, as they transition in either direction. Assuming the output low voltage, V<sub>OL</sub>, is 0.2V and the output high voltage, V<sub>OH</sub>, is 3.2V, and that the charge/discharge current is constant at I<sub>SC</sub>, then the current spike will exist for a time, T, where,

$$T = C_L \times (V_{OH} - V_{OL})/I_{SC}$$
  
= 500 pF × 3.0 V/100 mA = 15 ns

 $C_L$  (500 pF) is the load capacitance of typically 64 to 88 dynamic RAMs, in other words, four banks comprising 16 data bits and possibly six check bits if error correction is required.

In fact, due to the trace inductance, the rate of change of current will not be a step function, so that the current waveform looks like a spike. Even so, the rapid rate of change of current, di/dt, into the trace inductance L, will create a potentially excessive voltage "e" across this inductance. As an example, if the current changes from 0 to 100 mA in 6 ns, and the composite trace inductance is  $0.3\mu$ H, then the voltage across this inductance is "e," where,

e = L di/dt= 0.3  $\mu$ H × 100 mA/6 ns = 5 V

In other words, at this rate of change in current, even a small inductance can be dangerous for two reasons. First, the dynamic RAMs at the far end of the trace could be destroyed, unless they have clamping diodes to  $V_{CC}$  and GND (most do not), or second, the returning voltage may exceed the threshold it has just passed causing a second and then third change of state. If this sudden glitch occurs on a control signal input such as  $\overline{RAS}$ , the memory contents may be inadvertently changed.

It is therefore necessary to remove the spike. The most common approach is to insert a damping resistor in the path between the driver and the RAMs, fairly close to the

driver, as shown by RD in Figure 2a. The best value for the resistor is the critical value giving a critically damped transition. Too high a value will cause overdamping which results in a slow transition. This slow edge may create excessive skew problems and slow down the memory cycle, or even worse, the edge may be slow enough that the RAM cycle never begins internally. If the damping resistor value is too low, the undershoot or overshoot may not be removed. It is therefore recommended that the resistor be determined on the first prototypes (not wire-wrapped prototypes because the value will be different due to the larger distributed inductance and capacitance). Also, the values may be different for the control lines, particularly CAS. If there are a number of banks, and a RAS is used to select each bank, then the damping resistor in this line will be higher.

Typical values for the damping resistors will be between 15 $\Omega$  and 100 $\Omega$ , the lower the loading, the higher the values. Some IC manufacturers offer octal memory drivers with on-chip series resistors fixed at ~25 $\Omega$ . Unless this is the critical value required for all the lines, problems will arise. The DP8400 family has been designed with equivalent internal values of approximately 10 $\Omega$ , allowing for any external value of damping resistor.

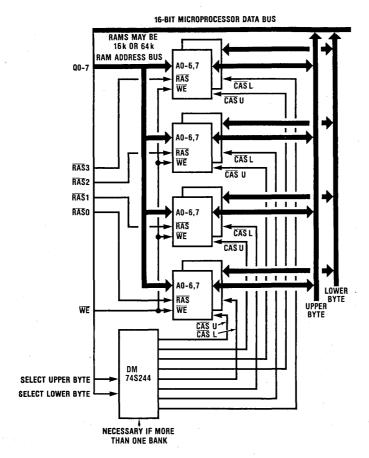


Figure 1. Typical 16-Bit Memory with Byte Write Address

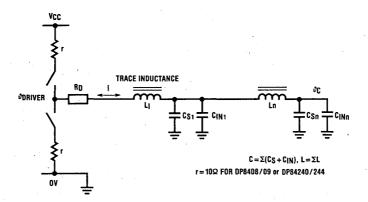


Figure 2a. Complex Load Impedance Caused by Distributed Trace inductance L and Capacitance  $C_S$ , and RAM input Capacitance  $C_{IN}$ 

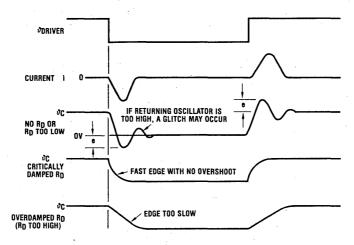


Figure 2b. Timing Waveforms Showing the Effect of Variations of R<sub>D</sub> on Signals Appearing at the RAM

### **Switching Current Spikes**

Another major undesirable effect of the fast current spikes is the effect on the  $V_{CC}$  and GND pins. The worst case is when all eight or nine address outputs switch in the same direction at the same time, as shown in Figure 3a. If each driver can source or sink 100mA, then a current of approximately 1 A could enter or exit the driver chip in a period of 20ns. The resistance and inductance of the  $V_{CC}$  and GND lines to the chip can cause excessive drops during this switching time (see waveforms in Figure 3a), which may, in turn, upset latches either in the DP8408/DP8409, or externally. A ceramic capacitor connected across  $V_{CC}$  and GND pins will largely remove the spike. A  $1\mu F$  multilayer ceramic is recommended. This should be fitted as close as possi-

ble to the pins in order to reduce lead inductance. The DP8408/DP8409 pin configuration facilitates this with GND and  $V_{CC}$  pins 0.2" apart so that the ceramic capacitor can be fitted as close to the chip as possible. The second GND pin should also be decoupled. These GND and  $V_{CC}$  pins are located in the center of the package to reduce bonding lead lengths. In fact, the lead resistance is five times lower than if the supply pins were in the corners. An example of how this spike can be reduced would be the previous example of a 1A change in supply current switching in 20 ns with a  $1\mu F$  ceramic capacitor decoupling GND and  $V_{CC}$ . The voltage drop "v" is  $1A\times 20\, ns/1\mu F$ , or 20 mV.

7

If the decoupling capacitor was  $0.01\mu F$ , the drop would be 2V. Tantalum or other types of capacitors are lower frequency capacitors and have only a small effect in reducing the voltage spike. Ceramic capacitors are high frequency, and multilayer capacitors with lower inductance have a greater effect in reducing the voltage spike and are therefore recommended. As a further recommendation, the dynamic RAMs should be similarly decoupled with approximately a  $0.1\mu F$  ceramic capacitor on each RAM. Wire-wrapped boards, in particular, need special attention.

There are some other precautions that may be considered when driving memories. First, be aware that IC

sockets increase load capacitance and inductance, so it becomes a matter of the importance of removability of chips, and maintainability. Also, shorter, thicker trace lengths will reduce the load, and good GND and  $V_{CC}$  connections will help reduce the voltage spikes around the memory board. For wire-wrapped designs, GND and  $V_{CC}$  should be multiwired.

With proper decoupling and correct selection of damping resistors, integrated circuit dynamic RAM controllers will function as expected to ease the burden of the system designer.

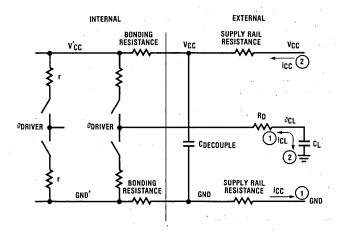


Figure 3a. Effect of Switching All Outputs Simultaneously in the Same Direction

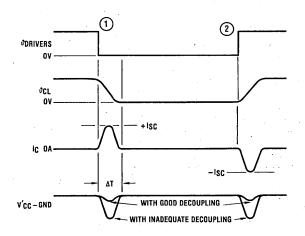


Figure 3b. Timing Waveforms Showing Internal Supply Rail Drops During Output Switching

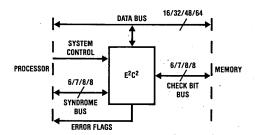


## **Dynamic Memory Support**

## DP8400 — E<sup>2</sup>C<sup>2</sup> Expandable Error Checker and Corrector

## **General Description**

The DP8400 Expandable Error Checker and Corrector  $(E^2C^2)$  aids system reliability and integrity by detecting errors in memory data and correcting single or double-bit errors. The  $E^2C^2$  data I/O port sits across the processormemory data bus as shown, and the check bit I/O port connects to the memory check bits. Error flags are provided, and a syndrome I/O port is available. Fabricated using high speed Schottky technology in a 48-pin dual-in-line package, the DP8400 has been designed such that its internal delay times are minimal, maintaining maximum memory performance.



For a 16-bit word, the DP8400 monitors data between the processor and memory, with its 16-bit bidirectional data bus connected to the memory data bus. The DP8400 uses an encoding matrix to generate 6 check bits from the 16 bits of data. In a WRITE cycle, the data word and the corresponding check bits are written into memory. When the same location of memory is subsequently read, the  $E^2C^2$  generates 6 new check bits from the memory data and compares them with the 6 check bits read from memory to create 6 syndrome bits. If there is a difference (causing some syndrome bits to go high), then that memory location contains an error and the DP8400 indicates the type of error with 3 error flags. If the error is a single-bit error, the DP8400 will automatically correct it.

The DP8400 is easily expandable to other data configurations. For a 32-bit data bus with 7 check bits, two DP8400s can be used in cascade with no other ICs. Three DP8400s can be used for 48 bits, and four DP8400s for 64 data bits, both with 8 check bits. In all these configurations, single and double-error detection and single-error correction are easy to implement.

When the memory is more unreliable, or better system integrity is preferred, then in any of these configurations, double-error correction can be performed. One approach requires a further memory WRITE-READ cycle using complemented data and check bits from the DP8400. If at least one of the two errors is a hard error, the DP8400 will correct both errors. This implementation requires no more memory check bits or DP8400s than the single-error correct configurations.

The DP8400 has a separate syndrome I/O bus which can be used for error logging or error management. In addition, the DP8400 can be used in BYTE-WRITE applications (for up to 72 data bits) because it has separate byte controls for the data buffers. In 16 or 32-bit systems, the DP8400 will generate and check system byte parity, if required, for integrity of the data supplied from or to the processor. There are three latch controls to enable latching of data in various modes and configurations.

## **Operational Features**

- Fast single and double-error detection
- Fast single-error correction
- Double-error correction after catastrophic failure with no additional ICs or check bits
- Functionally expandable to 100% double-error correct capability
- Functionally expandable to triple-error detect
- Directly expandable to 32 bits using 2 DP8400s only
- Directly expandable to 48 bits using 3 DP8400s only
- Directly expandable to 64 bits using 4 DP8400s only
- Expandable to and beyond 64 bits in fast configuration with extra ICs
- 3 error flags for complete error recording
- 3 latch enable inputs for versatile control
- Byte parity generating and checking
- Separate byte controls for outputting data in BYTE-WRITE operation
- Separate syndrome I/O port accessible for error logging and management
- On-chip input and output latches for data bus, check bit bus and syndrome bus
- Diagnostic capability for simulating check bits
- Memory check bit bus, syndrome bus, error flags and internally generated syndromes available on the data bus
- Self-test of E<sup>2</sup>C<sup>2</sup> on the memory card under processor control
- Full diagnostic check of memory with the E<sup>2</sup>C<sup>2</sup>
- Complete memory failure detectable
- Power-on clears data and syndrome input latches

## **Timing Features**

#### **16-BIT CONFIGURATION**

WRITE Time: 35 ns from data-in to check bits valid
DETECT Time: 35 ns from data-in to Any Error (AE) flag set
CORRECT Time: 70 ns from data-in to correct data out

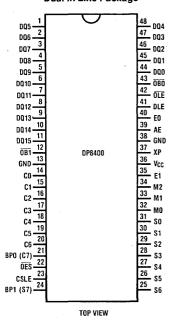
## Timing Features (Continued)

#### 32-BIT CONFIGURATION

WRITE Time: 65 ns from data-in to check bits valid DETECT Time: 60 ns from data-in to Any Error (AE) flag set CORRECT Time: 125 ns from data-in to correct data out

## **DP8400 Connection Diagram**

## **Dual-In-Line Package**



Order Number DP8400N-4 or DP8400D-4 See NS Package N48A or D48A

## Pin Definitions See Figure 1 for abbreviations

 $V_{CC}$ , GND, GND:  $5.0V \pm 5\%$ . The 3 supply pins have been assigned to the center of the package to reduce voltage drops, both DC and AC. Also there are two ground pins to reduce the low-level noise. The second ground pin is located two pins from  $V_{CC}$ , so that decoupling capacitors can be inserted directly next to these pins. It is important to adequately decouple this device, due to the high switching currents that will occur when all 16 data bits change in the same direction simultaneously. A recommended solution would be a 1 μF multilayer ceramic capacitor in parallel with a low-voltage tantalum capacitor, both connected close to pins 36 and 38 to reduce lead inductance.

**DQ0-DQ15:** Data I/O port. 16-bit bidirectional data bus which is connected to the input of DIL0 and DIL1 and the output of DOB0 and DOB1, with DQ8-DQ15 also to CIL.

C0-C6: Check-bit I/O port. 7-bit bidirectional bus which is connected to the input of the CIL and the output of the COB. COB is enabled whenever M2 is low.

**S0-S6:** Syndrome I/O port. 7-bit bidirectional bus which is connected to the input of the SIL and the output of the SOB.

**DLE:** Input data latch enable. When high, DILO and DIL1 outputs follow the input data bus. When low, DILO and DIL1 latch the input data.

CSLE: Input check bit and syndrome latch enable. When high, CIL and SIL follow the input check and syndrome bits. When low, CIL and SIL latch the input check and syndrome bits. If OES is low, SIL remains latched.

OLE: Output latch enable. OLE enables the internally generated data to DOL0, and DOL1, COL and SOL when low, and latches when high.

XP: Multi-expansion, which feeds into a three-level comparator. With XP at 0V, only 6 or 7 check bits are available for expansion up to 40 bits, allowing byte parity capability. With XP open or at  $V_{CC}$ , expansion beyond 40 bits is possible, but byte parity capability is no longer available. When XP is at  $V_{CC}$ , CG6 and CG7, the internally generated upper two check bits, are set low. When XP is open, CG6 and CG7 are set to word parity.

**BP0 (C7):** When XP is at 0V, this pin is byte-0 parity I/O. In the Normal WRITE mode, BP0 receives system byte-0 parity, and in the Normal READ mode outputs system byte-0 parity. When XP is open or at  $V_{CC}$ , this pin becomes C7 I/O, the eighth check bit for the memory check bits, for 48-bit expansion and beyond.

BP1 (S7): When XP is at 0V, this pin is byte-1 parity I/O. In the Normal WRITE mode, BP1 receives system byte-1 parity, and in the Normal READ mode outputs system byte-1 parity. When XP is open or at V<sub>CC</sub>, this pin becomes S7 I/O, the eighth syndrome bit for 48-bit expansion and beyond.

**AE:** Any error. In the Normal READ mode, when low, AE indicates no error and when high, indicates that an error has occurred. In any WRITE mode, AE is permanently low.

E0: In the Normal READ mode, E0 is high for a single-data error, and low for other conditions. In the Normal WRITE mode, E0 becomes PE0 and is low if a parity error exists in byte-0 as transmitted from the processor.

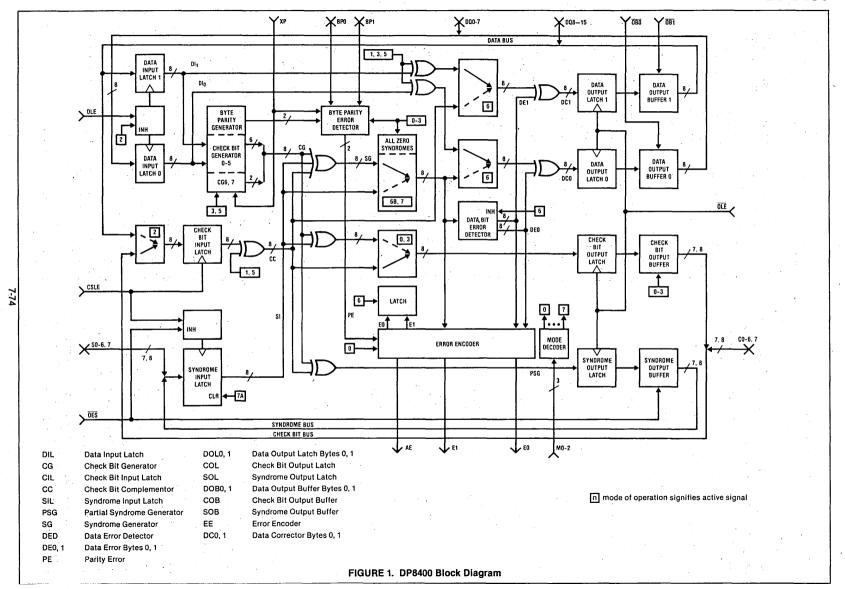
E1: In the Normal READ mode, E1 is high for a single-data error or a single check bit error, and low for no error and double-error, in the Normal WRITE mode, E1 becomes PE1 and is low if a parity error exists in byte-1 as transmitted from the processor.

OBO, OB1: Output byte-0 and output byte-1 enables. These inputs, when low, enable DOL0 and DOL1 through DOB0 and DOB1 onto the data bus pins DQ0-DQ7 and DQ8-DQ15. When OB0 and OB1 are high the DOB0, DOB1 outputs are TRI-STATE®.

OES: Output enable syndromes. I/O control of the syndrome latches. When high, SOB is TRI-STATED and external syndromes pass through the syndrome input latch with CSLE high. When OES is low, SOB is enabled and the generated syndromes appear on the syndrome bus, also CSLE is inhibited internally to SIL.

M0, M1, M2: Mode control inputs. These three controls define the eight major operational modes of the DP8400. Table III depicts the modes.

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## SYSTEM WRITE (Figure 2a)

The Normal WRITE mode is mode 0 of Table III. Referring to the block diagram in Figure 9a and the timing diagram of Figure 9b, the 16 bits of data from the processor are enabled into the data input latches, DILO and DIL1, when the input data latch enable (DLE) is high. When this goes low, the input data is latched. The check bit generator (CG) then produces 6 parity bits, called check bits. Each parity bit monitors different combinations of the input data-bits. In the 16-bit configuration, assuming no syndrome bits are being fed in from the syndrome bus into the syndrome input latch, the 6 check bits enter the check bit output latch (COL), when the output latch enable OLE is low, and are latched in when OLE goes high. Whenever M2 (READ/ WRITE) is low, the check bit output buffer COB always enables the COL contents onto the external check bit bus. Also the data error decoder (DED) is inhibited during WRITE so no correction can take place. Data output latches DOL0 and DOL1, when enabled with OLE, will therefore see the contents of DILO and DIL1. If valid system data is still on the data bus, a memory WRITE will write to memory the data on the data bus and the check bits output from COB. If the system has vacated the data bus, output enables ( $\overline{OB0}$  and  $\overline{OB1}$ ) must be set low so that the original data word with its 6 check bits can be written to memory.

#### SYSTEM READ

There are two methods of reading data: the error monitoring method (Figure 2b), and the always correct method (Figure 2c). Both require fast error detection, and the second, fast correction. With the first method, the memory data is only monitored by the  $E^2C^2$ , and is assumed to be correct. If there is an error, the Any Error flag (AE) goes high, requiring further action from the system to correct the data. With the always correct method, the memory data is assumed to be possibly in error. Memory data is removed and the corrected, or already correct, data is output from the  $E^2C^2$  by enabling  $\overline{OB1}$  and  $\overline{OB0}$ . To detect an error (referring to Figures 10a and 10b) first DLE and CSLE

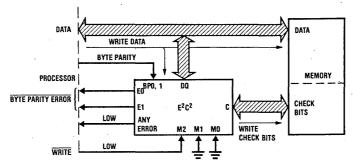


FIGURE 2a. Normal WRITE Mode with E<sup>2</sup>C<sup>2</sup>

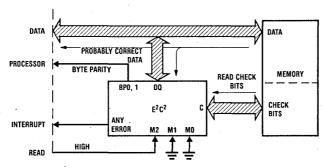


FIGURE 2b. Normal READ Mode, Error Monitoring Method with E<sup>2</sup>C<sup>2</sup>

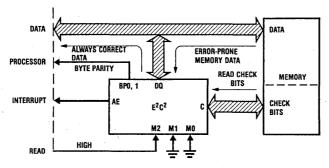


FIGURE 2c. Normal READ Mode, Always Correct Method with E<sup>2</sup>C<sup>2</sup>

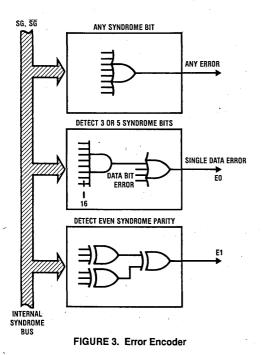
go high to enter data bits and check bits from memory into DILO, DOL1 and CIL. The 6 check bits generated in CG from DILO and DOL1 are then compared with CIL to generate syndromes on the internal syndrome bus (SG). Any bit or bits of SG that go high indicate an error to the error encoder (EE).

If data correction is required  $\overline{OB0}$  and  $\overline{OB1}$  must be set low (after memory data has been disabled) to enable data output buffers DOB0 and DOB1. The location of any data bit error is determined by the data error decoder (DED), from the syndrome bits. The bit in error is complemented in the DOL for correction. The other 15 bits from DED pass the DIL contents directly to the DOL, so that DOL now contains corrected data.

#### **ERROR DETERMINATION**

The three error flags, for a 16-bit example, are decoded from the internally generated syndromes as shown in *Figure 3*. First, if any error has occurred, the generated check bits will be different from the memory check bits, causing some of the syndrome bits to go high. By OR-ing the syndrome bits, the output will be an indication of any error.

If there is a single-data error, then (from the matrix in Table IV) it can be seen that any data error causes either 3 or 5 syndrome bits to go high. 16 AND gates decode which bit is in error and the bit in error is XOR-ed with the corresponding bit of the DIL to correct it, whereas the other 15 decoder outputs are low, causing the corresponding 15 bits in DIL to transfer to DOL directly. DOL now contains corrected data. The 16 AND gate outputs are OR-ed together causing E0 to go high, so that E0 is the single-data-error indication. If the error is a double-error, then either 2,



4 or 6 of the syndrome bits will be high. The syndromes for two errors (including one or two check bit errors) are the two sets of syndromes for each individual error bit, XOR-ed together. By performing a parity check on the syndrome bits, flag E1 will indicate even/odd parity. If there is still an error, but it is not one of these errors, then it is a detectable triple-bit error. Some triple-bit errors are not detectable as such and may be interpreted as single-bit errors and falsely corrected as single-data errors. This is true for all standard ECC circuits using a Modified Hamming-code matrix. The DP8400 is capable, with its Rotational Syndrome Word Generator matrix, of determining all triple-bit errors using twice as many DP8400s and twice as many check bits.

#### **ERROR FLAGS**

Three error flags are provided to allow full error determination. Table I shows the error flag outputs for the different error types in Normal READ mode. If there is an error, then ANY ERROR will go high, at a time  $t_{\mbox{\scriptsize DEV}}\mbox{\it (Figure 10b)}$  after data and check bits are presented to the DP8400. The other two error flags E0 and E1 become valid  $t_{\mbox{\scriptsize DE0}}\mbox{\it and}$   $t_{\mbox{\scriptsize DE1}}\mbox{\it later}.$ 

The error flags differentiate between no error single check bit error, single data-bit error, double-bit error. Because the DP8400 can correct double errors, it is important to know that two errors have occurred, and not just a multiple-error indication. The error flags will remain valid as long as DLE and CSLE are low, or if DLE is high, and data and check bits remain valid.

## **BYTE PARITY SUPPORT**

Some systems require extra integrity for transmission of data between the different cards. To achieve this, individual byte parity bits are transmitted with the data bits in both directions. The DP8400 offers byte parity support for up to 40 data bits. If the processor generates byte parity when transferring information to the memory, during the WRITE cycle, then each byte parity bit can be connected to the corresponding byte parity I/O pin on the DP8400, either BP0 or BP1. The DP8400 develops its own internal byte parity bits from the two bytes of data from the processor, and compares them with BP0 and BP1 using an exclusive-OR for both parities. The output of each exclusive-OR is fed to the error flags E0 and E1 as PE0 and PE1, so that a byte parity error forces its respective error flag low, as in Table II. These flags are only valid for the Normal WRITE (mode 0) and XP at 0V. The DP8400 checks and generates even byte parity.

When transferring information from the memory to the processor, the DP8400 receives the memory data, and outputs the corresponding byte parity bits on BP0 and BP1 to the processor. The processor block can then check data integrity with its own byte parity generator. If in fact memory data was in error, the DP8400 derives BP0 and BP1 from the memory input data, and not the corrected data, so when corrected data is output from the DP8400, the processor will detect a byte parity error.

If correct byte parity is required, transfer of corrected output data in the DOL to DIL will result in correct byte parity at BP0 and BP1. This can be part of a normal memory re-WRITE cycle once an error has occurred.

## TABLE I. ERROR FLAGS AFTER NORMAL READ (MODE 4)

AE	E1	E0	Error Type
0	0	0	No error
1	1	0	Single check bit error
1	1	1	Single-data error
1	0	0	Double-bit error
	All Others		Invalid conditions

## TABLE II. ERROR FLAGS AFTER NORMAL WRITE (MODE 0)

AE	E1 (PE1)	E0 (PE0)	Error Type
0	1	1	No parity error
0	1	0	Parity error, byte 0
0	0	1	Parity error, byte 1
0	0	0	Parity error, bytes 0, 1

## TABLE III. DP8400 MODES OF OPERATION

Mode	M2 (R/W)	M1	MO	ŌĒS	Operation									
0	0	0	0	Х	Normal WRITE DIL → DOL, CG → COL → COB									
1	0	0	1	Х	Complement WRITE  DIL → DOL, CIL → COL → COB									
2	0	1	0	Х	Diagnostic WRITE, DLE inhibited DQ8-DQ15 ⊕ CG → SOL → SOB DQ8-DQ15 → CIL → COL → COB									
3	0	1	1	Х	Complement data only WRITE  DIL → DOL, (CG0, 1, 4, 5, CG2, CG3) → COL → COB									
4	1 .	0	0	Х	Normal READ DIL ⊕ DE → DOL, CIL → COL									
5	1	0	1	Х	Complement READ DIL ⊕ DE → DOL, CIL → COL									
6A	1	1	0	0	READ generated syndromes, check bit bus, error flags, SG0-SG6-DQ0-DQ6, CIL0-CIL6-DQ8-DQ14, E1-DQ7, E0-DQ15									
6B	1	1	0	1	READ syndrome bus, check bit bus, error flags, SIL0-SIL6 → DQ0-DQ6, CIL0-CIL6 → DQ8-DQ14, E1 → DQ7, E0 → DQ15									
7A	1	1	1	0	Generated syndromes replace with zero 0 → SIL → SG, CIL → COL, DIL ⊕ DE → DOL									
7B	1	1	1	1	Generated syndromes replace SIL → SG, CIL → COL, DIL ⊕ DE → DOL									

TABLE IV. DATA-IN TO CHECK BIT GENERATE, OR DATA BIT ERROR TO SYNDROME-GENERATE MATRIX (16-BIT CONFIGURATION)

DQ0-15 GENERATE CHECK BITS -1. **GENERATED** 2\* GENERATED CHECK 3\* **SYNDROMES** BITS 0. • 5 Ε D C. F F 

HEXADECIMAL EQUIVALENT
OF SYNDROME BITS

<sup>\*</sup> C2, C3 generate odd parity

#### MODES OF OPERATION

There are three mode-control pins, M2, M1 and M0, offering 8 major modes of operation, according to Table III.

M2 is the READ/WRITE control. In normal operation, mode 0 is Normal WRITE and mode 4 is Normal READ. By clamping M0 and M1 low, and setting M2 low during WRITE and high during READ, the DP8400 is very easy to use for normal operation. The other modes will be covered in later sections.

## 16-Bit Configuration

The first two rows on top of the check bit generate matrix (Table IV) indicate the data position of DQ0 to DQ15. The left side of the matrix, listed 0 to 5, corresponds to syndromes S0 to S5. S0 is the least significant syndrome bit. There are two rows of hexadecimal numbers below the matrix. They are the hex equivalent of the syndrome patterns. For example, syndrome pattern in the first column of the matrix is 001011. Its least significant four bits (0010) equal hexadecimal 4, and the remaining two bits (11) equal hexadecimal 3.

Check bit generation is done by selecting different combinations of data bits and generating parities from them. Each row of the check bit generate matrix corresponds to the generation of a check bit numbered on the right hand side of the matrix, and the ones in that row indicate the selection of data bits.

The following are the check bit generate equations for 16-bit wide data words:

- CG0 = DQ2 + DQ3 + DQ4 + DQ5 + DQ6 + DQ7 + DQ9 + DQ10 + DQ11 + DQ13 + DQ14 + DQ15
- CG1 = DQ3 + DQ6 + DQ8 + DQ9 + DQ11 + DQ13 + DQ14 + DQ15
- \*CG2 = DQ0 DQ3 DQ4 DQ8 DQ10 DQ12 DQ13 DQ14 DQ15 0 1
- \*CG3 = DQ1 

  DQ2 

  DQ7 

  DQ8 

  DQ9 

  DQ10 

  DQ12 

  DQ14 

  DQ15 

  1
- CG4 = DQ0 @ DQ1 @ DQ5 @ DQ7 @ DQ8 @ DQ11 @ DQ13 @ DQ15
- CG5 = DQ0 + DQ1 + DQ2 + DQ4 + DQ5 + DQ6 + DQ8 + DQ12 + DQ13 + DQ14

\*CG2 and CG3 are odd parities.

The following error map (Table V) depicts the relationship between all possible error conditions and their associated syndrome patterns. For example, if a syndrome pattern is S0-5=111101, data bit 14 is in error.

Figure 4 shows how to connect one DP8400 in a 16-bit configuration, in order to detect and correct single or double-

bit errors. For a Normal WRITE, processor data is presented to the DP8400, where it is fed through DIL0 and DIL1 to the check bit generator. This generates 6 parity bits from different combinations of data bits, according to Table IV. The numbers in the row below the table are the hexadecimal equivalent of the column bits (with bits 6, 7 low). A '1' in any row indicates that the data bit in that column is connected to the parity generator for that row. For example, check bit 1 generates parity from data bits 3, 6, 8, 9, 11, 13, 14, and 15.

Check bits 0, 1, 4, 5, and 6 generate even parity, and check bits 2 and 3 generate odd parity. This is done to insure that a total memory failure is detected. If all check bits were even parity, then all zeros in the data word would generate all check bits zero and a total memory failure would not be detected when a memory READ was performed. Now allzero-data bits produce C2 and C3 high and a total memory failure will be detected. When reading back from the same location, the memory data bits (possibly in error) are fed to the same check bit generator, where they are compared to the memory check bits (also possibly in error) using 6 exclusive-OR gates. The outputs of the XORs are the syndrome bits, and these can be determined according to Table IV for one data bit error. For example, an error in bit 2 will produce the syndrome word 101001 (for S5 to S0 respectively). The syndrome word is decoded by the error encoder to the error flags, and the data-error decoder to correct a single data bit error. Assuming the memory data has been latched in the DIL, by making DLE go low, memory data can be disabled. Then by setting OBO and OB1 low, corrected data will appear on the data bus. The syndromes are available as outputs on pins S0-5 when OES is low. It is also possible to feed in syndromes to SIL when OES is high and CSLE goes high. This can be useful when using the Error Management Unit shown in Figure 4. C6 and S6 are not used for 16 bits. It is safe therefore to make C6 appear low, through a 2.7 kΩ resistor to ground. The same applies for S6 if syndromes are input to the DP8400. If OES is permanently low, S6 may be left open.

Any 16-bit memory correct system using the DP8400 without syndrome inputs must keep the  $\overline{\text{OES}}$  pin grounded, then all the syndrome I/O pins may be left open. The reason for this is that the DP8400 resets the syndrome input latch at power up. If the  $\overline{\text{OES}}$  pin is grounded, the syndrome input latch will remain reset for normal operations.

The parameter t<sub>NMR</sub> (see *Figure 10b*), new mode recognized time, is measured from M2 (changing from READ to WRITE) to the valid <u>check</u> bits appearing on the check bit bus, provided the <u>OLE</u> was held low.

TABLE V. SYNDROME DECODE TO BIT IN ERROR FOR 16-BIT DATA WORD

	S0	. 0	4.		4		1	_		0	-		-		4	^	
Syndro		0	,	4	1	0	ó	4	1	0	ó	4	1	0	,	1	1
-		1	Ū	1	1	0	U	1	1	•	-	1		Ū	U	1	1
Bits	S2	0	0	0	0	1	1	1	1	0	0	0	0	1	1	1	. 1
	S3	0	0	0	0	0	0	0	0	1	1	1	1	1	1	1	1
<b>S</b> 5	S4	1															
0	0	NE	CO	C1	D	C2	D	D	3	СЗ	D	D	9	D	10	Т	D
0	1	C4	D	D	11	D	T	T	۵	D	7	۲	ם	Т	D	D	15
1	0	C5	D	D	6	D	4	Т	D	D	2	۲	۵	12	D	D	14
1	1 ,	D	5	T	D	0	D.	D	13	1	D	D	T	D	T.	8	D

NE = no error

Cn = check bit n in error
D = two bits in error

T = three errors detected

Number = single data bit in error

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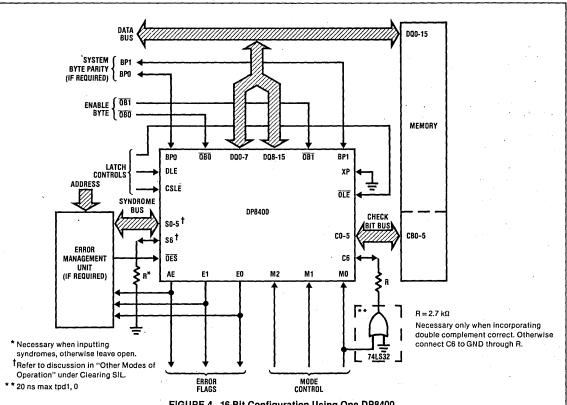
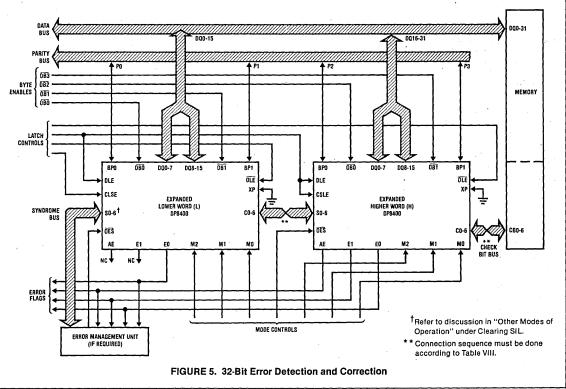


FIGURE 4. 16-Bit Configuration Using One DP8400



The parameter  $t_{MCR}$  (see Figure 10b), mode change recognized time, is measured from M2 (changing from WRITE to READ) when both E1 and E2 become invalid. This is required when a memory correcting system properties the DP8400 with byte parity checking. The E1 and E2 pins flag the byte parity error in a memory WRITE cycle. When the DP8400 switches to a subsequent memory READ cycle, it requires  $t_{MCR}$  for E1 and E2 to be switched to flag any READ error(s).

### **EXPANDED OPERATION**

## 32-Bit Configuration

Figure 5 shows how to connect two DP8400s in cascade to detect single and double bit errors, and to correct single data errors. The same circuit will also correct double bit errors once a double-error has been detected, provided at least one error is a hard error. The lower chip L is in effect a slave to the higher chip H, which controls the memory check bits and error reporting. The check bit bus of L is reordered and connected to the syndrome bus of H, as shown in Figure 5.

In a Normal WRITE mode, referring to Figures 13a, 13b, and 13c, the 6 check bits generated from the lower 16 bits (CGL) are transferred via the COL to the COB of L, provided  $\overline{\text{OLE}}$  is high and M2 ( $\overline{\text{R/W}}$ ) of L is low. These partial check bits from L then appear at SIL of H, so that with CSLE high, they combine with the 6 check bits generated in H with an overlap of one bit, to produce 7 check bits. With M2 ( $\overline{\text{R/W}}$ ) of H low, these 7 check bits are output from COB to memory.

A READ cycle may consist of DETECT ONLY or DETECT THEN CORRECT, depending on the system approach. In both approaches, L writes its partial check bits, CGL, to H as in WRITE mode. H develops the syndrome bits from CGL, CGH and the 7 check bits read from memory in CIL. H then outputs from its error encoder (EE) if there is an error. If corrected data is required, H already knows if it has a single-data error from its syndrome bits, but if not, it must transfer partial syndromes back to L. These partial syndromes PSH, (CGH XOR-ed with CIL), are stored in SOL of H. L must therefore change modes from WRITE to READ, while Houtputs the partial syndromes from its SOB by setting OES low. The partial syndromes are fed into CIL of L and XOR-ed with CGL to produce syndrome bits at SGL. The data error decoder, DED, then corrects the error in L. The DED of H will already have corrected an error in the higher 16 bits. Only one error in 32 bits can be corrected as a single-data error, the chip with no error does not change the contents of its DIL when it is enabled in DOL. Table VI shows the 3 error flags of H, which become valid during the DETECT cycle. E0 of L becomes valid during the CORRECT cycle, so that the 4 flags provide complete error reporting.

TABLE VI. ERROR FLAGS AFTER NORMAL READ (32-BIT CONFIGURATION)

AE (H)	E1 (H)	E0 (H)	E0 (L)*	Error Type
0	0	0	0	No error
1	1	0	0	Single-check bit error
1	1	1	0	Single-data bit error (H)
1	1	0	1	Single-data bit error (L)
1	0	0	0	Double-bit error
	All O	thers	Invalid conditions	

<sup>\*</sup> E0 (L) is valid after transfer of partial syndromes from higher to lower

### Equations for 32-bit expansion:

 $t_{DCB32} = t_{DCB16} + t_{SCB16} \\ t_{DEV32} = t_{DCB16} + t_{SEV16} \\ t_{DCD32} \text{ (High Chip)} = t_{DCB16} + t_{SCD16} \\ t_{DCD32} \text{ (Low Chip)} = t_{DCB16} + t_{BR}^* + t_{CCD16} \\ t_{BB} : \text{Bus reversing time (25 ns)}$ 

#### 32-Bit Matrix

Table VII shows a 32-bit matrix using two DP8400s in cascade as in Figure 5. This is one of 12 matrices that work for 32 bits. The matrix for bits 0 to 15 (lower chip) is the matrix of Table IV for 16-bit configuration, with row 6 always '0'. The matrix for bits 16 to 31 (higher chip) uses the same row combinations but interchanged, for example, the 3rd row (row 2) of L matrix is the same as the 6th row (row 5) of the H matrix. This means row 5 of H is in fact check bit 2 of H. Thus, the 6th row (row 5) combines generated check bit 5 (CG5) of L and generated check bit 2 of H. Check bit 5 of L therefore connects to the syndrome bit 2 (CG2) of H, and the composite generated check bit is written to check bit 2 of memory. Thus C2 performs a parity check on bits 0, 1, 2, 4, 5, 6, 8, 12, 13, 14, of L, and bits 16, 19, 20, 24, 26, 28, 29, 30, 31, of H. CG2 and CG3 generate odd parity, so that CG5 of L generates even parity which combines with CG2 of H generating odd parity. CG3 of L and CG3 of H both generate odd parity causing C3 to memory to represent even parity. Only 6 check bits are generated in each chip, the 7th (CG6) is always zero with XP grounded. Thus CG6 of L combines with CG0 of H so that C0 to memory is the parity of bits 18, 19, 20, 21, 22, 23, 25, 26, 27, 29, 30, 31. Similarly C6 to memory is only CG2 of L. The 7 composite generated check bits of H can now be written to memory.

When reading data and check bits from memory, CG6-CG0 of L are combined with CG6-CG0 of H in the same combination as WRITE. Memory check bits are fed into C6-C0 of H and compared with the 7 combined parity bits

TABLE VII. DATA BIT ERROR TO SYNDROME-GENERATE MATRIX (32-BIT CONFIGURATION)

1 1 1 1 1 1 1 1 1 1 2 2 2 2 2 2 2 2 2 2 2 3 3 DQ0-31 0 1 2 3 4 5 6 7 8 9 0 1 2 3 4 5 6 7 8 9 0 1 2 3 4 5 6 7 8 9 0 1 0 0 1 1 1 1 1 1 0 1 1 1 0 1 1 1 0 0 0 1 0 0 1 0 1 1 0 1 0 1 1 1 1 0 0 0 1 0 0 1 0 1 1 0 1 0 1 1 1 1 1 1 0 1 0 0 0 1 1 1 0 5 \*2 1.001100010101111 6 **GENERATED** SYNDROMES \*3 0 1 1 0 0 0 0 1 1 1 1 0 1 0 1 1 0 1 1 0 0 0 0 1 1 1 1 0 1 0 1 1 3 CHECK BITS 1 1 0 0 0 1 0 1 1 0 0 1 0 1 0 1 1 1 0 0 0 1 0 1 1 0 0 1 0 1 0 1110111010001110 1001100010101111 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 1 1 1 1 1 1 0 1 1 1 0 1 1 8 9 7 5 1 3 9 E B D 3 C 7 F F 2 A A 1 2 2 3 8 B 9 8 1 A 3 B 9 0 3 3 2 0 2 3 2 1 3 0 0 1 2 3 2 1 3 1 4 6 6 5 4 5 3 4 6 5 2 7 6 7 1 \* CG2, CG3 generate odd parity

## TABLE IX. SYNDROME DECODE TO BIT IN ERROR FOR 32-BIT DATA WORD

Syndr Bits	ome	S0 S1 S2 S3	0 0 0	1 0 0 0	0 1 0 0	1 1 0 0	0 0 1 0	1 0 1 0	0 1 1 0	1 1 1 0	0 0 0 1	1 0 0 1	0 1 0 1	1 1 0 1	0 0 1 1	1 0 1	0 1 1	1 1 1
S6	S5	S4	ĺ															
0	0	0	NE	C0	C1	D	C2	D	D	3	С3	D	D	9	D	10	Т	D
0	0	1	C4	D	D	11	D	T	T	D	D	7	17	D	T	D	D	15
0	1	0	C5	D	D	6	D	4	T	D	D	2	28	D	12	D	D	14
0	1	1	D	5	16	D	0	D	D	13	1	D	D	24	D	T	8	D
1	0	0	C6	D	D	22	D	Т	Т	D	D	25	18	D	T	D	D	Т
1	0	1	D	27	21	D	T	D	D	Т	23	D	D	T	D	T	Т	D
1	1	0	D	19	20	D	T	D	D	T	26	D	D	30	D	T	Т	D
1	1	1	Т	D	D	29	D	Т	Т	D	, D	31	Т	D	Т	D	D	T

NE = no error

Cn = check bit n in error

D = two bits in error

T = three errors detected

Number = single data bit in error

in H, to produce 7 syndrome bits S6–S0. H can now determine if there is any error, and if it has a single-data error, it can locate it and correct it without transferring partial syndromes to L. As an example of a DETECT cycle, CG5 of L combines with CG2 of H and is compared in H with memory check bit 2.

If L is now set to mode 4, Normal READ, and  $\overline{\text{OES}}$  of H is set low, the partial syndromes of H (CG6-CG0 of H XOR-ed with C6-C0 of H) are transferred and shifted to L. L receives these partial syndromes (S6-S0 of H) as check bit inputs C2, C1, C4, C3, C5, C0, C6 respectively, and compares them with CG6-CG0 respectively, to produce syndrome bits S6-S0. L now decodes these syndromes to correct any single-data error in data bits 0 to 15. For example, partial syndrome bit 2 of H combines with generated check bit 5 of L to produce syndrome bit 5 in L. An error in data bit 10 will create syndrome bits in L as 0001101 from S6-S0, and these will appear on S6-S0 of L with  $\overline{\text{OES}}$  low. An error in H will appear as per the H matrix. For example, an error in bit 16 will cause S6-S0 of L to be 0110010.

If  $\overline{\text{OES}}$  of L is set low, this syndrome combination appears on pins S6 to S0. For errors in bits 0 to 15, the syndrome outputs will be according to Table VII. For errors in bits 16 to 31, the syndrome outputs from L will still be according to Table VII due to the shifting of partial syndrome bits from H to L. The syndrome outputs from L are unique for each of the possible 32 bits in error.

If there is a check bit error, only one syndrome bit will be high. For example, if C5 is in error, then S1 of L will be high. For double-errors, an even number of syndrome bits will be high, derived from XOR-ing the two single-bit error syndromes. As mentioned previously, this is only one of the 12 approaches to connecting two chips for 32 bits, 6 of which are mirror images.

Table VIII depicts the exact connection for 32-bit expansion. LS equals syndrome bits of L. LC equals check bits of L. HS equals syndrome bits of H. HC equals check bits of H. Syndrome bits S0 to S6 of L are connected to system syndrome bits S0 to S6. LC and HS columns are lined together showing the check bit port of L connected to the syndrome port of H in the exact sequence as shown in Table VIII. For example, check bit C0 of L is connected to the syndrome bit S1 of H, and check bit C6 of L is connected to the syndrome bit S0 of H. Check bits of H are connected to the system check bits in the order shown. Check bit C1 of H is connected to the system check bit C0.

## **Expansion for Data Words Requiring 8 Check Bits**

For 16-bit and 32-bit configurations, XP is set permanently low. In 48-bit or 64-bit configurations, XP is either set permanently to  $V_{CC}$  or left open, according to Table X, to provide 8 check bits and syndrome bits.

TABLE X. XP: EXPANSION STATUS

XP	Status	Data Bus
ov	BP0 and BP1 are byte parity I/O CG6 = 0	< 40 Bits
Open	No byte parity I/O, CG6 and CG7 = word parity	≥40 Bits
V <sub>CC</sub>	No byte parity I/O, CG6 and CG7 = 0	≥40 Bits

## 48-Bit Expansion

Three DP8400s are required for 48 bits, with the higher chip using all 8 of its check bits to the memory. No byte parity is available for 48 or 64 bits. XP of all three chips must be at  $V_{\rm CC}$ . The three chips are connected in cascade

## TABLE XI. CHECK BIT PORT TO SYNDROME PORT INTERCONNECTIONS FOR EXPANSION TO 48 BITS

		LL S	LL	LH S	LH C	HL S	HL C		
	S0	0	0	1.	1	6	6	CO	
	S1	1	1	5	5	1	1	C1	
Syndrome I/O	S2	2	2	6	6	4	4	C2	Check Bit I/O
to	S3	3	3	3	3	7	7	C3	1 . [
Management	S4	4	4	4	4	2	2	C4	to
Management	S5	5	5	2	2	3	3	C5	Memory
	S6	6	6	0	0	5	5	C6	
	S7	7	7	7	7	0	0	C7	

For example: S0 of LL is connected to system syndrome S0. C0 of LL is connected to S1 of LH. C1 of LH is connected to S6 of HL. C6 of HL is connected to system check bit C0.

#### TABLE XII. SYNDROME DECODE TO BIT IN ERROR FOR 48-BIT DATA WORD

-	S0	0	1	0	1	0 -	1	0	1	0	1	0	1	0	1	0	1
Syndrome	S1	0	0	1	1	0	0	1	1	0	0	1	1	0	0	1	1
Bits	S2	0	0	0	0	1	· 1	1	1	0	0	0	0	1	1	1	1
	S3	0	0	0	0	0	0	0	0	1	1	1	1	1	1	1	1
S7 S6 S5	S4																
0 0 0	0	NE	CO	C1	D	C2	D	D	3	C3	D	D	9	D	10	Т	D
0 0 0	1	C4	D	D	11	D	T	Т	D	D	7	17	D	Т	D	D	15
0 0 1	0	C5	D	D	6	D	4	T	D	D	2	28	D	12	D	D	14
0 0 1	1	ם	5	16	D	0	D	D	13	1	D	Δ	24	D	Т	8	ם
0 1 0	0	C6	D	D	22	D	Т	Т	D	D	25	18	D	Т	D	D	T
0 1 0	1	ם	27	21	D	32	D	D	Т	23	D	D	Т	D	Т	Т	D
0 1 1	0	D	19	20	D	33	D	D	T	26	D	D	30	D	Т	Т	D
0 1 1	1	44	D	D	29	D	T	40	D	D	31	T	D	Т	D	D	T
1 0 0	0	C7	D	D	Т	D	T	43	D	D	Т	۲	D	Т	D	D	Т
1 0 0	1	. D	Т	35	D	T	D	D	T	T	D	D	T	D.	Т	Т	D
1 0 1	0	D	Т	41	D	39	D	D	T	Т	D	D	Τ	D	Т	Т	D
1 0 1	1	42	D	D	T	D	Т	47	D	D	T	Т	D	T	D	D	Т
1 1 0	0	Ď	Т	.38	D	37	D	D	Т	T	D	D	Т	D	Т	·T	D
1 1 0	1	36	D	D	T	D	T	45	D	D	Т	T	D	Т	D	D	Т
1 1 1	0	34	D	D	Т	D	T	T	D	D	Т	T	D	T	D	D	T
1 1 1	1	D	Т	46	D	Т	D	D	Т	Т	D	D	Т	D	Т	Т	D

NE = no error

Number = single data bit in error

Cn = check bit n in error
D = two bits in error

T = three errors detected

as in Figure 6, but with the HH chip removed. The error flags are as Table XV, but with AE (HH) and E1 (HH) becoming AE (HL) and E1 (HL), and E0 (HH) removed.

## 48-Bit Matrix

The matrix for 48 bits is that for 64 bits shown (in Table XVI) but only using bits 0 to 47. This is one of many matrices for 48-bit expansion using the basic 16-bit matrix. The matrix shown uses 2 zeroes for CG6 and CG7, for all three chips, with XP set to  $V_{CC}$ . Other matrices may use CG6 and CG7 as word parity with XP open.

## 64-Bit Expansion

There are two basic methods of expansion to 64 bits, both requiring 8 check bits to memory, and four DP8400s. One is the cascade method of *Figure* 6, requiring no extra ICs. With this method partial check bits have to be transferred through three chips in the WRITE or DETECT mode, and partial syndrome bits transferred back through three chips in CORRECT mode. This method is similar to *Figure* 5, 32-bit approach. The connections between the

check bit bus and syndrome bus for each of the chip pairs are shown in Table XIII.

The error flags of HH are valid during the DETECT cycle as in Table XV, and the other error flags are valid during the CORRECT cycle.

A faster method of 64-bit expansion shown in Figure 7 requires a few extra ICs, but can WRITE in 57 ns, DETECT in 57 ns or DETECT THEN CORRECT in 116 ns. In the WRITE mode, all four sets of check bits are combined externally in the 8 74S280 parity generators. These generate 8 composite check bits from the system data, which are then enabled to memory. In the DETECT mode, again 8 composite check bits are generated, from the memory data this time, and compared with the memory check bits to produce 8 external syndrome bits. These syndrome bits may be OR-ed to determine if there is any error. By making the 74S280 outputs SYNDROMES, then any bit low causes the 74S30 NAND gate to go high, giving any error indication. To correct the error, these syndrome bits are fed re-ordered into SIL of each DP8400 now set to mode 7B. This enables the syndromes directly to SG and then

DED of each chip. One chip will output corrected data, while the other three output non-modified data (but still correct).

### Equations for fast 64-bit expansion:

 $\begin{array}{l} t_{DCB64} = \ t_{DCB16} + t_{pd} \, (74S280) + t_{pd} \, (74S240) \\ t_{DEV64} = \ t_{DCB16} + t_{pd} \, (74S280) + t_{pd} \, (74S30) \end{array}$ 

 $t_{DCD64} = t_{DCB16} + t_{pd} (74S280) + t_{pd} (74ALS533)$ 

+ t<sub>SCD16</sub>

#### 64-Bit Matrix

With the 64-bit matrix shown in Table XVI, it is necessary to set at least one chip with CG6, CG7 non-zero. The highest chip, connected to data bits 48 to 63, has XP set open, so that its CG6 and CG7 are word parity. The syndrome word of the highest chip will now have either 5 or 7 syndrome bits high, but inside the chip CG6 and CG7 remove two of these in a READ so that the chip sees the normal 3 or 5 syndrome bits.

## TABLE XIII. CHECK BIT PORT TO SYNDROME PORT INTERCONNECTIONS FOR EXPANSION TO 64 BITS

		LL S	LL C	LH S	LH C	HL S	HL C	нн S	HH C		-
	S0 S1	0	0	1 5	1 5	6 1	6 1	7 0	7 0	C0 C1	
Syndrome I/O to Management	S2 S3 S4 S5 S6 S7	2 3 4 5 6 7	2 3 4 5 6 7	6 3 4 2 0	6 3 4 2 0	4 7 2 3 5	4 7 2 3 5	1 2 3 4 5 6	1 2 3 4 5 6	C2 C3 C4 C5 C6	Check Bit I/O to Memory

For example: S0 of LL is connected to system syndrome S0. C0 of LL is connected to S1 of LH. C1 of LH is connected to S6 of HL. C6 of HL is connected to S7 of HH. C7 of HH is connected to system check bit C0.

### TABLE XIV. SYNDROME DECODE TO BIT IN ERROR FOR 64 BIT DATA WORD

Syndrome S	S0 S1 S2 S3	0 0 0 0	1 0 0	0 1 0 0	1 1 0 0	0 0 1 0	1 0 1 0	0 1 1 0	1 1 1 0	0 0 0 1	1 0 0	0 1 0 1	1 1 0 1	0 0 1 1	1 0 1	0 1 1	1 1 1
S7 S6 S5 S	54																
0 0 0 0	0	NE	0	C1	D	C2	D	D	3	СЗ	D	D	9	D	10	Т	D
000	1 [	C4	D	D	11	D	Т	T	D	D	7	17	D	Т	D	D	15
0 0 1 0	0	C5	О	D	6	D	4	T	D	D	2	28	D	12	D	D	14
0 0 1	1	D	5	16	۵	0	D	D	13	1	D	۵	24	D	T	8	D
~0100	ο [	C6	D	D	22	D	Т	T	۵	D	25	18	D	Т	D.	D	Т
0 1 0	1	D	27	21	D	32	D	D	Т	23	D	Ď	Т	D	Т	Т	D
0 1 1 (	o L	D	19	20	D	33	D	D	Т	26	D	D	30	D	T	T	D
0 1 1	1	44	D	D	29	D	T	40	D	D	31	T	D	T	D	D	Т
1000	o L	C7	D	D	Т	D	Т	43	D	D	Т	Т	D	T	D	D	51
100	1 [	D	Т	35	D	Т	D	D	57	Т	D	D	58	D	T	T	D
1 0 1 (	o L	D	T	41	D	39	D	D	59	T	D	D	T.	D	Т	T	D
1 0 1	1 _	42	D	D	55	D	Т	47	D	D	Т	T	D	T	D	D	63
1 1 0 0	o [	D	Т	38	D	37	D	D	54	Т	D	D	52	D	T	Т	D
1 1 0	1	36	D	D	50	D	Т	45	D	D	60	T	D	Т	D	D	62
1111	0	34	О	D	53	D	T	T	۵	۵	48	Т	D	T	۵	D	61
1 1 1	1	D	49	46	D	Т	D	D	Т	Т	D	D	Т	D	56	Т	D

NE = no error

Cn = check bit n in error

T = three errors detected

Number = single data bit in error

D = two bits in error

### TABLE XV. ERROR FLAGS AFTER NORMAL READ (ANY 64-BIT CONFIGURATION)

AE (HH)	E1 (HH)	E0 (HH)	E0 (HL)	E0 (LH)	EO (LL)	Error Type
0	0	0	0	0	0	No error
1	1	0	0	0	0	Single-check bit error
1	1	1	0	0	0	Single-data bit error in HH
1	1	0	1	0	0	Single-data bit error in HL
1	1	0	0	1	0	Single-data bit error in LH
1	1	0	0	0	1	Single-data bit error in LL
1	0	0	0	0	0	Double-error

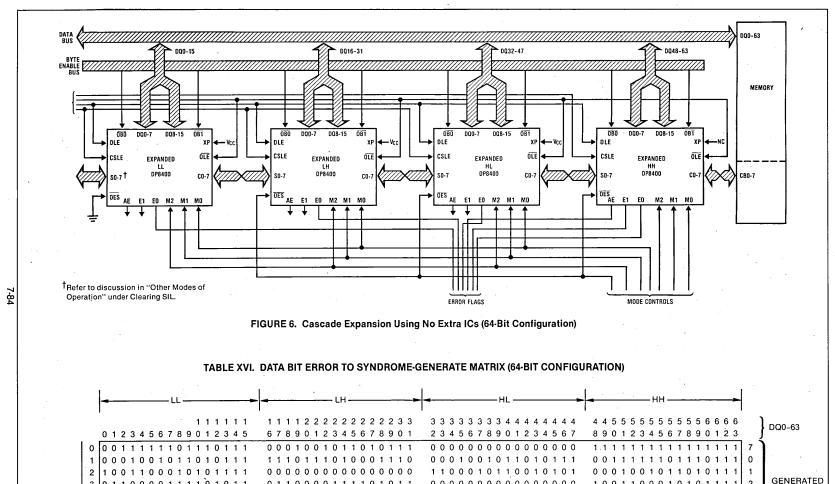
CHECK

BITS

5

6

EFD8CECBF99ADEDB



0011111101110111

00000000000000000

1 1 0 0 0 1 0 1 0 1 1 1 1

1110111010001110

0011111101110111

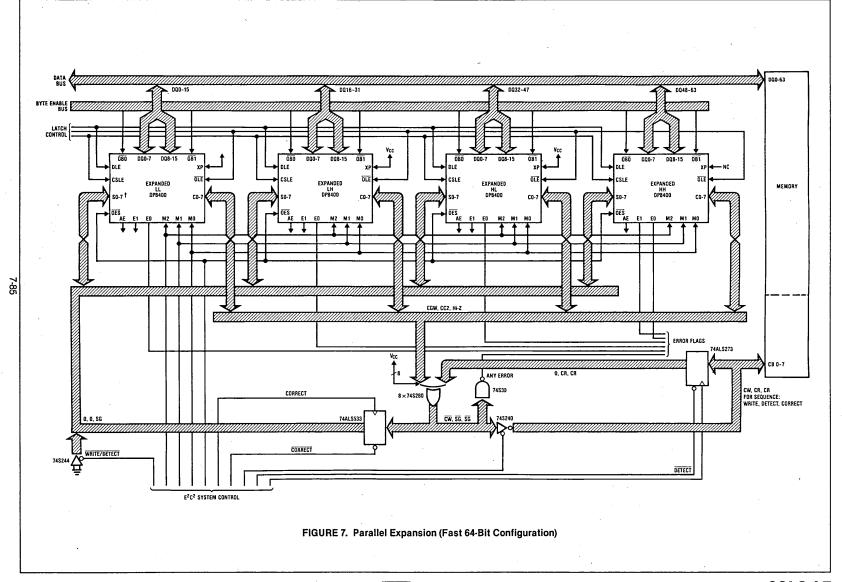
5 6 E 9 D C C A 7 A B 8 7 D F B

**SYNDROMES** 

7 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0

48975139EBD3C7FF

3 3 2 0 2 3 2 1 3 0 0 1 2 3 2 1



#### OTHER MODES OF OPERATION

### Double Error Correction, using the Double-Complement Approach

The DP8400 can be made to correct two errors, using no extra ICs or check bits, if at least one of the two errors detected is a hard error. This does require an extra memory WRITE and READ. Nevertheless, if a permanent fallure exists, and an additional error occurs (creating two errors), both errors can be corrected, thereby saving a system crash.

Once a double error has been detected, the system puts the DP8400 in COMPLEMENT mode by setting M0 high. First a WRITE cycle is required and M2 is set low, putting the chip in mode 1, Table III, (COMPLEMENT WRITE), so that the contents of DIL are complemented into DOL, and the contents of CIL complemented into COL. D80 and OB1 are set low so that complemented data and check bits can be written back to the same location of memory. Writing back complemented data to a location with a hard

error forces the error to repeat itself. For example, if cell N of a particular location is jammed permanently high, and a low is written to it, a high will be read. However, when the data is complemented a low is again written, so that a high is read back for the second time. After a second READ (this second READ is a COMPLEMENT READ) of the location, data and check bits from the memory are recomplemented, so that bit N now contains a low. In other words, the error in bit N has corrected itself, while the other bits are true again. If there are two hard errors in a location, both are automatically corrected and the DP8400 detects no error on COMPLEMENT READ, as in Figure 8a. Figure 8b also shows that if one error is soft, the hard error will disappear on the second READ and the DP8400 corrects the soft error as a single-error. Therefore, in both cases, the DOL contains corrected data, ready to be enabled by OB0 and OB1. A WRITE to memory at this stage removes the complemented data written at the start of the sequence.

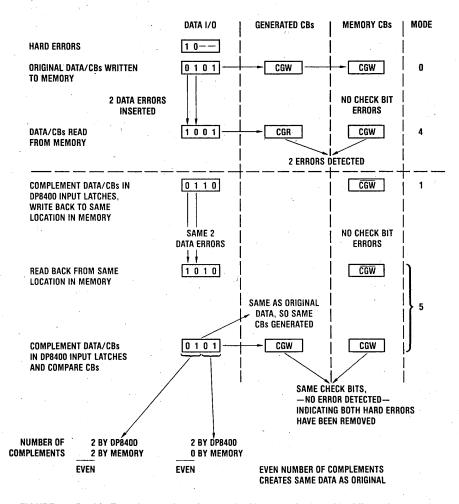


FIGURE 8a. Double Error Correct Complement Hard Error Method — 2 Hard Errors in Data Bits

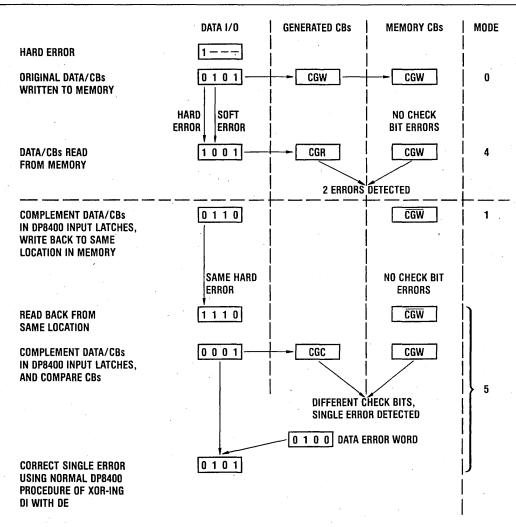


FIGURE 8b. Double Error Correct Complement Hard Error Method - 1 Hard Error, 1 Soft Error In Data Bits

The examples shown in *Figures 8a and 8b* are for 4 data bits. This approach will work for any number of data bits, but for simplicity these examples show how complementing twice corrects two errors in the data bits. The double COMPLEMENT approach also works for any two errors providing at least one is hard. In other words, one data-bit error and one check bit error, or two check bit errors are also corrected if one or both are hard. At the end of the COMPLEMENT READ cycle, the error flags indicate whether the data was correctable or not, as shown in Table XVII. If both the errors were soft, then the data was not correctable and the error flags indicate this.

This approach is ideal where double errors are rare but may occur. To avoid a system crash, a double-error detect now causes the system to enter a subroutine to set the DP8400 in COMPLEMENT mode. This method is also useful in bulk-memory applications, where RAMs are used with known cell failures, and is applicable in 16, 32, 48 or 64-bit configurations. In the 16-bit configuration, modes 1

and 5 of Table III are used. In the 32-bit expanded configuration, modes 1, 5 and 5 are used for the highest chip, and modes 3, 3 and 4 for the lower chip for WRITE, DETECT, and CORRECT. With the lower chip it is necessary to wrap around DOL (after latching its contents in mode 3), back to DIL and perform a Normal READ in mode 4 in the lower chip.

### TABLE XVII. ERROR FLAGS AFTER COMPLEMENT READ (MODE 5)

AE	E1	E0	Error Type
0	0	0	Two hard errors
1	1	0	One hard error, one soft check bit error
1	1	1	One hard error, one soft data bit error
1	0	0	Two soft errors, not corrected

### **Double-Error Correct with Error Logging**

Figures 4 and 5 show the  $E^2C^2$  syndrome port connected to an error management unit (EMU). This scheme stores syndromes and the address of locations that fail, thereby logging the errors. Subsequent errors in a memory location that has already stored syndromes in the EMU, can then be removed by injecting the stored syndromes of the first error. To save the addresses and syndromes when power to the EMU is removed, it is necessary to be able to transfer information via the  $E^2C^2$  syndrome port to the processor data bus. This is also useful for logging the errors in the processor. Transfer in the opposite direction is also necessary.

### **Data Bus to Syndrome Bus Transfer**

This is necessary when transferring syndrome information to the error management unit, which is connected to the external syndrome bus. First, data to make CG = 0 (all data bits high) must be latched in DIL. Then in mode 2, data is fed to CIL, XOR-ed with 0, and output via SOL with  $\overline{OES}$  low to the syndrome bus. Data is therefore fed directly from the system to the syndrome bus, and this cycle may be repeated as long as DLE is kept low, forcing CG to remain zero.

### Syndrome Bus to Data Bus Transfer

This is important when information in the error logger or error management unit has to be read. The DP8400 is set to mode 6B with OES high, and with OB0, OB1 and OLE low. If CSLE is high, the syndrome bus and check bit bus data appear on the lower and upper bytes of the data bus to be read by the system. Also E1 and E0 values that were valid when mode 6 was entered, appear on DQ7 and DQ15.

### **Full Diagnostic Check of Memory**

Using mode 2, it is possible to transfer the upper byte of the data bus directly to the CIL, with CSLE high, without affecting DIL. These simulated check bits then appear on the check bit bus with  $\overline{\text{OLE}}$  low, which also causes the previously latched contents of DIL to transfer to DOL. By enabling  $\overline{\text{OB0}}$  and  $\overline{\text{OB1}}$  data can be written to memory with the simulated check bits. A Normal READ cycle can then aid the system in determining that the memory bits are functioning correctly, since the processor knows the check bits and data it sent to the  $E^2C^2$ . Another solution is to put the  $E^2C^2$  in mode 6 and read the memory check bits directly back to the processor.

### Self-Test of the E2C2 On-Card

Again using mode 2, data written from the processor data bus upper byte to CIL may be stored in CIL, by taking CSLE low. Data can now be fed into DIL from the processor, with DLE set high, as in a Normal READ mode (mode 4). Providing CSLE is kept low, the DP8400 will use the simulated check bits in CIL to perform a diagnostic READ, with valid error reporting and correcting. This may be repeated with new data provided CSLE is kept low. In this way memory is not used, thus by reading corrected data in mode 4, and by reading the generated syndromes, and error flags E0 and E1, the DP8400 can be tested completely on-card without involving memory.

### Monitoring Generated Syndromes and Memory Check Bits

Mode 6A enables SG0-SG6 onto DQ0-DQ6, and CILO-CIL6 onto DQ8-DQ14, provided OLE, OB0 and OB1 are low. Also the two error flags, E1 and E0 (latched from the previous READ mode), appear on DQ7 and DQ15. This may be used for checking the internal syndromes, for reading the memory check bits, or for diagnostics by checking the latched error flags.

### Clearing SIL

In the 16-bit only configuration, or the lower chip of expanded configurations, and in various modes of operation in the higher expanded chips, it is required that SIL be maintained at zero. At power-up initialization, both SIL and DIL are reset to all low. If OES is kept low, SIL will remain reset because CSLE is inhibited to SIL. Another method is to keep OLE always high and the syndrome bus externally set low, or set low whenever CSLE can be used to clear SIL.

Mode 7A also forces the SIL to be cleared whenever CSLE occurs, and also these zero syndromes go to the internal syndrome bus SG. This puts the DP8400 in a PASS-THROUGH mode where the DIL contents pass to DOL and CIL contents to COL, if OLE is low.

### Power-Up Initialization of Memory

Both SIL and DIL are reset low at power-up initialization. This facilitates writing all zeroes to the memory data bits to set up the memory. The check bits corresponding to all-zero data will appear on the check bit bus if the DP8400 is set to mode 0 and  $\overline{\rm OLE}$  is set low. All-zero data appears on the data bus when  $\overline{\rm OB0}$  and  $\overline{\rm OB1}$  are also set low. The system can now write zero-data and corresponding check bits to every memory location.

### **Byte Writing**

Figure 14a shows the block diagram of a 16-bit memory correction system consisting of a DP8400 error correction chip and a DP8409 DRAM controller chip. There are 12 control signals associated with the interface. Six of the signals are standard DP8400 input signals, three are standard DP8409 input signals, and three are buffer control signals. The buffer control signals, PBUF0 and PBUF1, control when data words or bytes from the DP8400/memory data bus are gated to the processor are gated to the DP8400/memory data bus.

When the processor is reading or writing bytes to memory, words will always be read or written by the DP8400 and DP8409 error correction and DRAM controller section. The High Byte Enable and Address Data Bit Zero signals from the processor should control the byte transfers via the ocal bus transceiver signals PBUF0 and PBUF1. The buffer control signal, DOUTB, controls when data from memory is gated onto the DP8400/memory data bus.

Figure 14b shows the timing relationships of the 12 control signals, along with the DP8400/memory data bus and some of the DRAM control signals (RAS and CAS). RGCK is the RAS generator clock of the DP8409 which is used in Mode 1 (Auto Refresh mode), along with being the system clock.

Having two separate byte enable pins, OB0 and OB1, it is fairly easy to implement byte writing using the DP8400. First it is necessary to read from the location to which the byte is to be written. To do this the DP8400 is put in normal Read mode (Mode 4), which will detect and correct a single bit error. WIN is kept high and RASIN is pulled low, causing the DP8409, now in Mode 5 (Auto Access mode), to start a read memory cycle. The data word and check bits from memory are then enabled onto the DP8400/memory data bus by pulling DOUTB low. The data and check bits are valid on the bus after the RASIN to  $\overline{CAS}$  time (t<sub>RAC</sub>) plus the column access time (t<sub>CAC</sub>) of the particular memories used. DLE,CSLE can then be pulled low in order to latch the memory data into the input latches of the DP8400. Next OLE can be pulled low to enable the corrected memory word, or the original memory word if no error was present, into the data output latches. The corrected memory word will be available at the data output latches "tDCD16" after the memory word was available at the data input latches. Once the corrected data is available at the output latches OLE can be pulled high to latch the corrected data. After this DLE,CSLE can be pulled high in order to enable the input data latches again and DOUTB can be pulled high to disable the memory data from the DP8400/memory data bus.

There is no reason to use the data or check bit input latches (DLE,CSLE) of the DP8400 during the read cycle time period if the memory data and checkbits are valid throughout the cycle.

Now the DP8400 can be put into a write cycle (Mode 0 = M2 = Low). At this time the byte to be written to memory and the other byte from memory can be enabled onto the DP8400/memory data bus ( $\overline{OB0}$ ,  $\overline{PBUF1}$  or  $\overline{OB1}$ ,  $\overline{PBUF0}$  go low). DLE,CSLE can now transition low to latch the new memory word into the data input latch. Next  $\overline{OLE}$  is pulled low to enable the output latches. When the new checkbits are valid,  $t_{DCB16}$  after the data word is valid on the DP8400/memory data bus,  $\overline{OLE}$  and  $\overline{DLE}$  can be pulled high to latch the new memory word into the output latches, and then  $\overline{WIN}$  can be pulled low to write the data into memory.  $\overline{RASIN}$  should be held low long enough to cause the new data and check bits to be stored into memory ( $\overline{WIN}$  data hold time).

DLE,CSLE and OLE could transition high and low simultaneously instead of being sequenced as was done in this example.

Also a READ-MODIFY-WRITE cycle was performed, taking approximately 30% longer than a normal memory WRITE cycle. A READ and then a WRITE memory cycle could have been used in the above example but it would have taken longer.

Because data from the processor was valid at the same time as data from memory, memory buffers were used (PBUF0, PBUF1, DOUTB).

A byte READ from memory is no different from a normal READ. This approach may be used for a 16-bit processor using byte writing, or an 8-bit processor using a 16-bit memory to reduce the memory percentage of check bits, or with memory word sizes greater than two bytes.

### Beyond Single-Error Correct

With the advent of larger semiconductor memories, the frequency of the soft errors will increase. Also some memory system designers may prefer to buy less expensive memories with known cell, row or column failures, thus, more hard errors. All this means that double-error correct, triple-error detect capability, and beyond will become increasingly important. The DP8400 can correct two errors, provided one or both are hard errors, with no extra components, using the double complement approach. There are two other approaches to enhance reliability and integrity. One is to use the error management unit to log errors using the syndrome bus, and then to output these syndromes, when required, back to the DP8400.

### **Double Syndrome Decoding**

The other approach takes advantage of the Rotational Syndrome Word Generator matrix. This matrix is an improvement of the Modified Hamming-code, so that if, on a second DP8400, the data bus is shifted or rotated by one bit, and 2 errors occur, the syndromes for this second chip will be different from the first for any 2 bits in error. Both chips together output a unique set of syndromes for any 2 bits in error. This can be decoded to correct any 2-bit error. This is not possible with other Modified Hamming-code matrices.

Input Voltage

# Absolute Maximum Ratings (Note 1) Operating Conditions Storage Temperature Range -65°C to +150°C Min Max Unit Supply Voltage, V<sub>CC</sub> 7V V<sub>CC</sub>, Supply Voltage 4.75 5.25 V

TA, Ambient Temperature

70

5.5V

50 mA

Output Sink Current

Maximum Power Dissipation\* at 25°C

Molded Package 3269mW

Lead Temperature (Soldering, 10 seconds) 300°C

### **Electrical Characteristics** (Note 2) $V_{CC} = 5V \pm 5\%$ , $T_A = 0$ °C to 70°C unless otherwise noted

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IL</sub>	Input Low Threshold				0.8	V
V <sub>IH</sub>	Input High Threshold		2.0			V
V <sub>C</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>C</sub> = -18 mA		- 0.8	-1.5	٧
lıн	Input High Current	V <sub>IN</sub> = 2.7V		1	160	μА
I <sub>IH</sub> (XP)	Input High Current	V <sub>CC</sub> = Max, XP = 5.25V		2.5	3.6	mA
I <sub>IL</sub> (XP)	Input Low Current	V <sub>CC</sub> = Max, XP = 0V		- 2.5	- 3.6	mA
I <sub>IL</sub> (BP0/C7)	Input Low Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.5V	1.3	-100.0	- 500	μΑ
I <sub>IL</sub> (BP1/S7)	Input Low Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.5V		100.0	- 500	μΑ
I <sub>IL</sub> (CSLE)	Input Low Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.5V		- 150.0	<b>- 750</b>	μΑ
I <sub>IL</sub> (DLE)	Input Low Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.5V		- 200.0	- 1000	μА
I <sub>IL</sub>	Input Low Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.5V		- 50.0	- 250	. μΑ
l <sub>l</sub>	Input High Current (Max)	V <sub>IN</sub> = 5.5V (Except XP Pin)			1.0	mA
V <sub>OL</sub>	Output Low Voltage	I <sub>OL</sub> = 8 mA (Except BP0, BP1) I <sub>OL</sub> = 4 mA (BP0, BP1 Only)		0.3 0.3	0.5 0.5	V
V <sub>OH</sub>	Output High Voltage	I <sub>OH</sub> = -100 μA I <sub>OH</sub> = -1 mA	2.7 2.4	3.2 3.0		V
los	Output Short Current (Note 3)	V <sub>CC</sub> = Max		<b>–</b> 55	- 100	mA
Icc	Supply Current	V <sub>CC</sub> = Max		340	410	mA
C <sub>IN</sub> (I/O)	Input Capacitance All Bidirectional Pins	Note 4		8.0		pF
C <sub>IN</sub>	Input Capacitance All Unidirectional Input Pins	Note 4		5.0		pF

Note 1: "Absolute Maximum Ratings" are the values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

**Note 2:** All typical values are for  $T_A = 25$  °C and  $V_{CC} = 5.0$ V.

Note 3: Only one output at a time should be shorted.

Note 4: Input capacitance is guaranteed by periodic testing. F test = 10 kHz at 300 mV,  $T_A = 25$  °C.

Note 5: All switching parameters measured from 1.5V of input to 1.5V of output. Input pulse amplitude 0V to 3V,  $t_f = t_f = 2.5$  ns.

<sup>\*</sup>Derate molded package 26.2mW/\*C above 25 °C.

# DP8400-4 Switching Characteristics (Note 5) $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0$ °C to 70°C, $C_L = 50$ pF, unless otherwise noted.

Symbol	Parameter	Conditions	<b>3</b>	Min	Тур	Max	Units
t <sub>DCB16</sub>	Data Input Valid to Check Bit Valid	Figure 9b			35	55	ns
t <sub>DEV16</sub>	Data Input to Any Error Valid	Figures 10b, 11b			35	45	ns
t <sub>DCD16</sub>	Data Input Valid to Corrected Data Valid	Figure 10b, OBO, O	B1 Low		70	85	ns
t <sub>DSI</sub>	Data Input Set-Up Time Before DLE, CSLE H to L	Figures 10b, 13d		-	- 40	10	ns
t <sub>DHI</sub>	Data Input Hold Time After DLE, CSLE H to L	Figures 10b, 13d		16	10		ns
t <sub>DSO</sub>	Data Input Set-Up Time Before OLE L to H	Figure 10b		20	12		ns
t <sub>DHO</sub>	Data Input Hold Time After OLE L to H	Figure 10b		. 20	12		ns
t <sub>DE0</sub>	E0 Valid After AE Valid	Figures 9b, 10b, 13	d		20	30	ns
t <sub>DE1</sub>	E1 Valid After AE Valid	Figures 9b, 10b, 13	d		12	30	ns
t <sub>iEV</sub>	DLE, CSLE High to Any Error Flag Valid (Input Data Previously Valid)	Figure 10b	,		60	80	ns
t <sub>IEX</sub>	DLE, CSLE High to Any Error Flag Invalid	Figures 9b, 10b			60	77	ns
t <sub>ILE</sub>	DLE, CSLE High Width to Guarantee Valid Data Latched	Figures 10b, 13d	DLE CSLE	25 50			ns ns
t <sub>OLE</sub>	OLE Low Width to Guarantee Valid Data Latched	Figure 13d		25			ns
t <sub>ZH</sub>	High Impedance to Logic 1 from OB0, OB1, OES	Figures 9b, 10b			32	50	ns
	M2 H to L	Figure 13d			70	85	ns
t <sub>HZ</sub>	Logic 1 to High Impedance from OBO, OB1, OES, M2 L to H	Figures 9b, 10b, 13 C <sub>L</sub> = 15 pF	d,		25	40	ns
t <sub>ZL</sub>	High Impedance to Logic 0 from OB0, OB1, OES	Figures 9b, 10b			30	45	ns
	M2 H to L	Figure 13d			70	85	ns
t <sub>LZ</sub>	Logic 0 to High Impedance from OB0, OES, M2 H to L	Figures 9b, 10b, 13 C <sub>L</sub> = 15 pF	d		25	40	ns
t <sub>PPE</sub>	Byte Parity Input Valid to Parity Error Flags Valid	Figure 9b			40	55	ns
t <sub>DPE</sub>	Data In Valid to Parity Error Flags Valid	Figures 9b, 13d			60	75	ns
t <sub>DBP</sub>	Data in Valid to Byte Parity Output Valid	Figure 9b			36	50	ns
t <sub>MCR</sub>	Mode Change Recognize Time	Figures 9b, 10b			60	100	ns

# **DP8400-4 Switching Characteristics** (Continued) (Note 5) $V_{CC} = 5.0V \pm 5\%$ , $T_A = 0$ °C to 70°C, $C_L = 50$ pF, unless otherwise noted.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t <sub>NMR</sub>	New Mode Recognize Time	Figure 10b		60	100	ns
t <sub>CDV</sub>	Mode Valid to Complement Data Valid	Figure 11b		55	72	ns
t <sub>CCV</sub>	Mode Valid to Complement Check Bit Valid	Figure 11b		55	72	ns
t <sub>SCB</sub>	Syndrome Input Valid to Check Bit Valid	Figure 13d		28	41	ns
t <sub>SEV</sub>	Syndrome Input Valid (CGL) to Any Error Valid	Figure 13d		25	39	ns
tsco	Syndrome Inputs Valid to Corrected Data Valid	Figure 13d		55	75	ns
t <sub>DSB</sub>	Data Input Valid to Syndrome Bus Valid	Figure 13d, OES Low		45	58	ns
t <sub>CSB</sub>	Check Bit Inputs Valid to Syndrome Bus Valid	Figure 13d, OES Low		40	51	ns
t <sub>CEV</sub>	Check Bit Inputs Valid (PSH) to Any Error Valid	Figure 13d		35	45	ns
t <sub>CCD</sub>	Check Bit Input Valid (PSH) to Corrected Data Valid	Figure 13d		70	82	ns
t <sub>DCB32</sub>	Data Input Valid to Check Bit Valid	Figure 13d		63	96	ns
t <sub>DEV32</sub>	Data Input Valid to Any Error Valid	Figure 13d		60	94	ns
t <sub>DCD32</sub>	Data Input Valid to Corrected Data Out	Figure 13d, OB0, OB1 Low		125	157	ns

Note 1: "Absolute Maximum Ratings" are the values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: All typical values are for  $T_A = 25$  °C and  $V_{CC} = 5.0$ V.

Note 3: Only one output at a time should be shorted.

Note 4: Input capacitance is guaranteed by periodic testing. F test = 10 kHz at 300 mV,  $T_A = 25$  °C.

Note 5: All switching parameters measured from 1.5V of input to 1.5V of output. Input pulse amplitude 0V to 3V,  $t_f = t_f = 2.5$  ns.

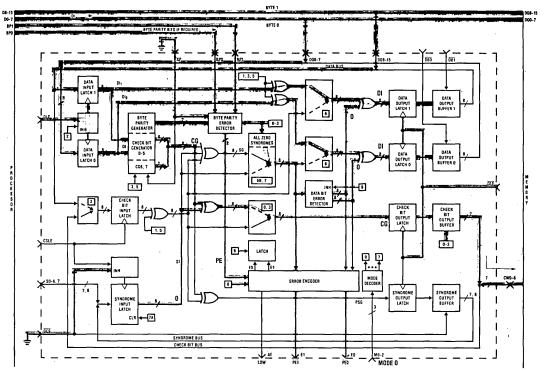


FIGURE 9a. DP8400 16-Bit Configuration, Normal WRITE with Byte Parity Error Detect If Required

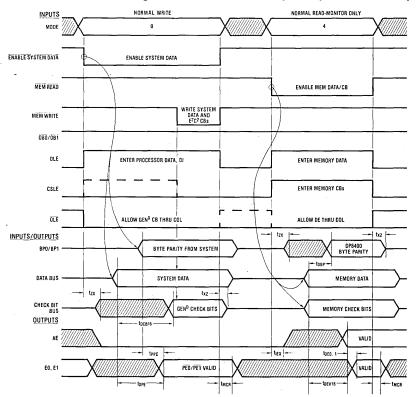


FIGURE 9b. DP8400 16-Bit Configuration, Normal WRITE and Normal READ Timing Diagram

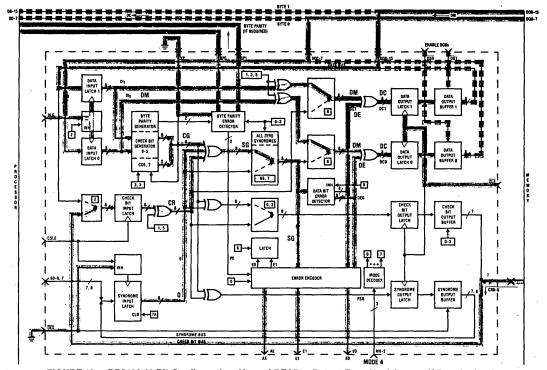
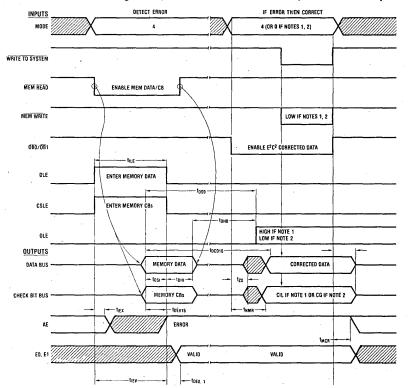


FIGURE 10a. DP8400 16-Bit Configuration, Normal READ — Detect Error (And Correct if Required ---)



Note 1: If rewriting correct data and CBs to same location and single data error was detected.

Note 2: If rewriting correct data and CBs to same location and single check bit error was detected.

FIGURE 10b. DP8400 16-Bit Configuration, DETECT THEN CORRECT Timing Diagram

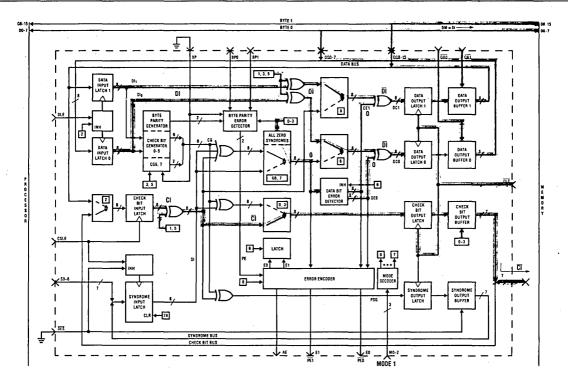
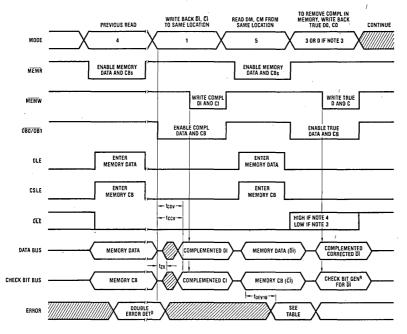


FIGURE 11a. DP8400 16-Bit Configuration, COMPLEMENT WRITE



Note 3: If rewriting corrected data and CBs back to same location and 1 soft data bit error was detected.

Note 4: If rewriting corrected data and CBs back to same location and 2 hard errors or 1 soft check bit was detected.

FIGURE 11b. DP8400 16-Bit Configuration, Detect 2 Errors, COMPLEMENT WRITE, COMPLEMENT READ, Output Corrected Data Timing Diagram

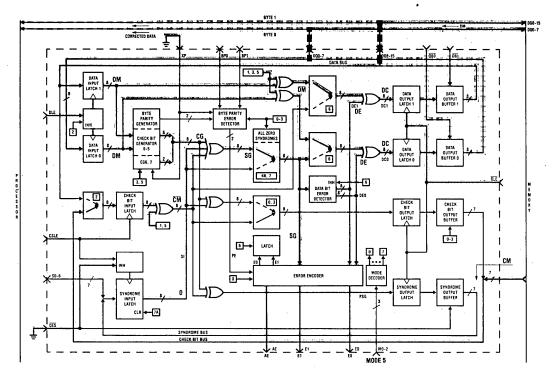


FIGURE 11c. DP8400 16-Bit Configuration, COMPLEMENT READ and Output Corrected if One or Two Hard Errors (---)

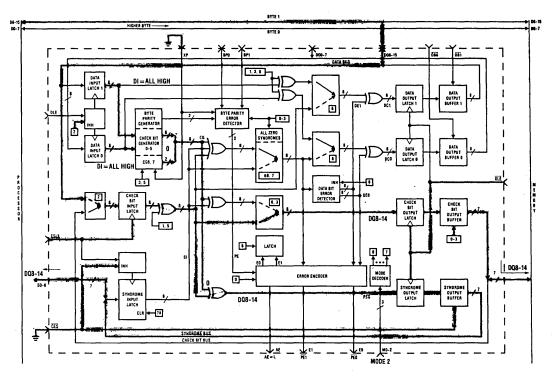


FIGURE 12a. DP8400 16-Bit Configuration, Diagnostic WRITE, READ. Data Bus to Check Bit Bus or Syndrome Bus (Providing DI = HIGH in Previous Cycle to Set CG = All Zero For Transfer to S).

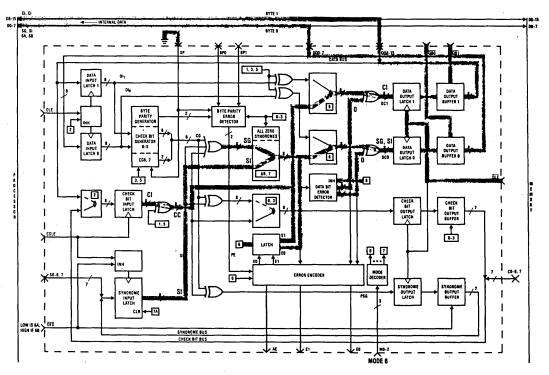


FIGURE 12b. DP8400 16-Bit Configuration, Monitor on Data Bus — Memory Check Bits

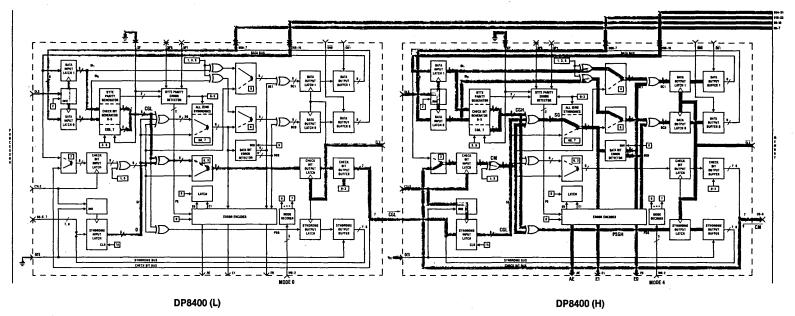
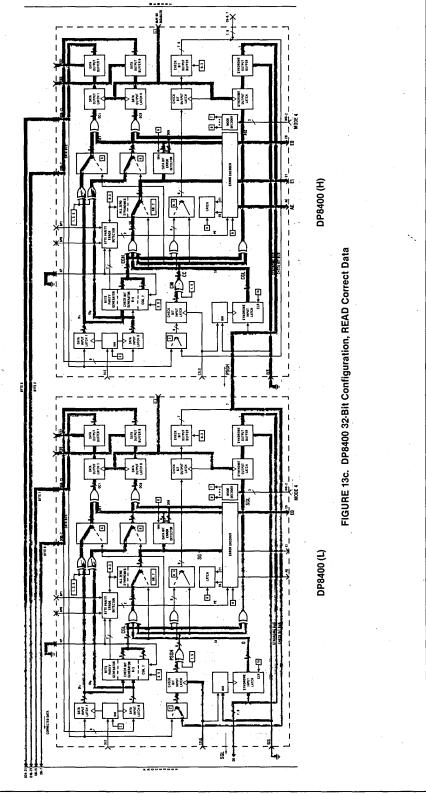
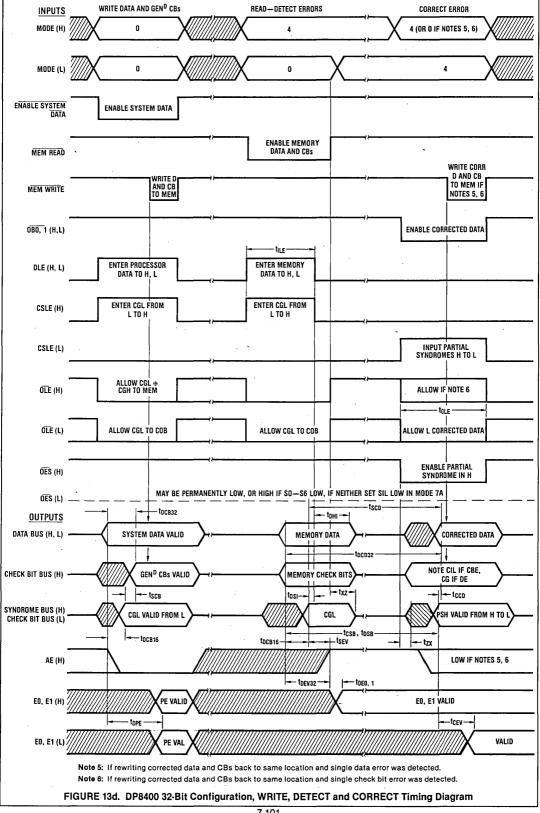
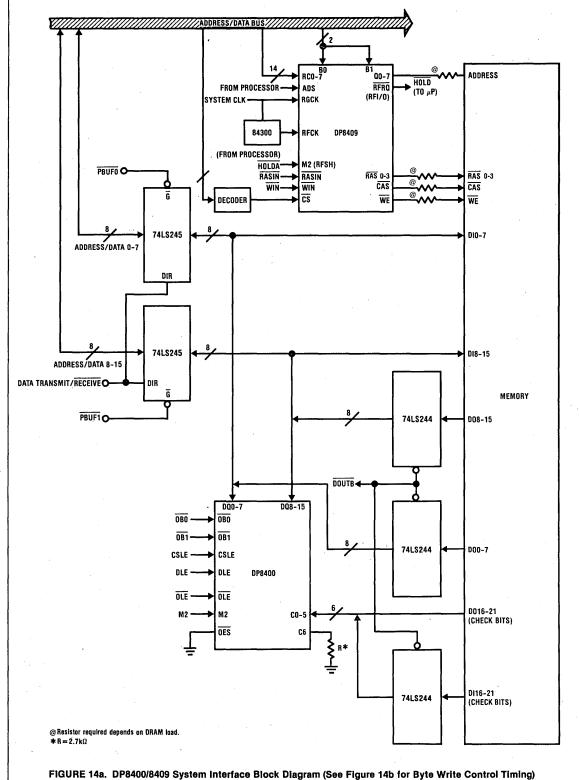


FIGURE 13b. DP8400 32-Bit Configuration, READ Detect Error Only







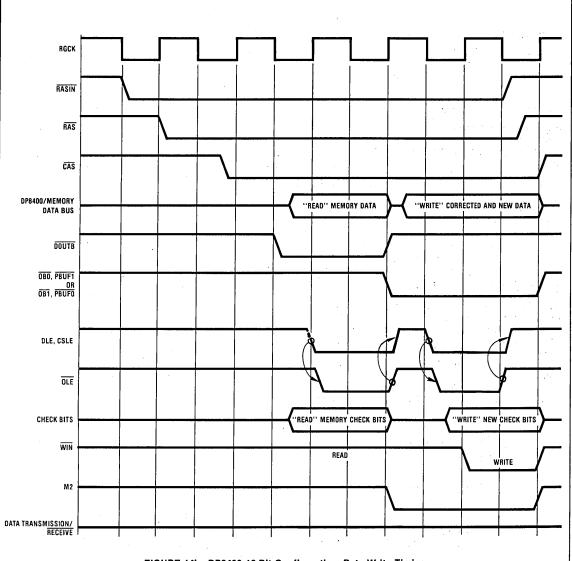


FIGURE 14b. DP8400 16-Bit Configuration, Byte Write Timing

# Expanding the Versatility of the DP8400

National Semiconductor Application Note AN-306 June 1982 Mike Evans



### **Basic Operation of the DP8400**

Introducing error correction capabilities to a memory incurs some penalties—extra memory, additional access times, and extra control circuitry. The DP8400 has been designed to minimize the last two, and for some data word widths, less extra memory is required than for other error correction circuits.

In systems using error correction, extra memory is needed for check bits, which are merely parity bits, each derived from different combinations of the data bits. If a single error does occur, the error correction circuit can determine which bit is in error and then complement that bit, to re-create the original data word. As the memory data word widens, the ratio of check bits to memory data bits is reduced. As a rough guide, starting with four data bits and four check bits, one additional check bit is required each time the data word doubles.

A circuit diagram of how the DP8400 generates the check bits in a write cycle and corrects errors in a read cycle is shown in *Figure 1a*, which uses four data bits and four check bits. A 4-bit example is shown in *Figure 1b*. In a write cycle, the data input latch, DIL, receives the system data and generates four parity bits or check bits, which pass through the check bit output latch, COL, and buffer, to be written to the selected memory location with the system data. This delays every write cycle, but fortunately the DP8400 takes only 30 ns extra to generate the (six) check bits. When this location is subsequently read, the four memory data bits pass through DIL to generate four new checks bits. The four memory check bits pass through the check bit input latch, CIL, and are

fed into four Exclusive-OR gates with the four generated check bits. The outputs of these gates are called syndrome bits, and obviously, if there are no errors, the two sets of check bits will be the same and no syndrome bits will go high. If there is an error in the check bits, only the corresponding syndrome bit will go high; in this case the data bits are still correct. If one of the data bits is in error, three syndrome bits will go high (in the case of DP8400, three or five will go high), and the syndrome word is unique for any of the bits in error. The four AND-gates decode which bit is in error and complement it out of the second set of Exclusive-OR gates. The other three output bits remain the same as the input bits, so the corrected word is now available to the system.

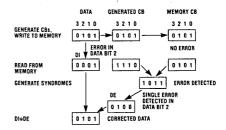


Figure 1b. Example of Single Error Correction

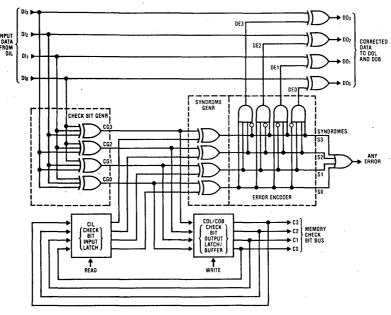


Figure 1a. Error Correction 4-Bit Functional Diagram

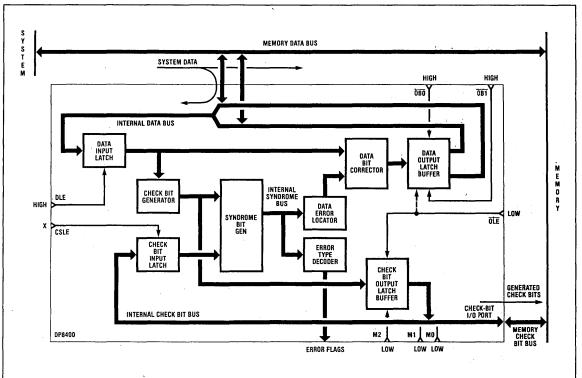


Figure 2a. DP8400 Read From Memory Cycle

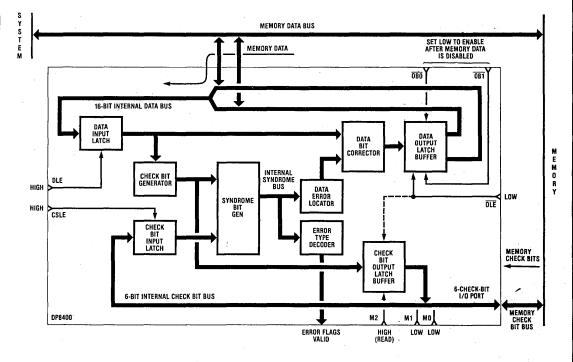


Figure 2a. DP8400 Write to Memory Cycle

In the case of the DP8400 with 16 data bits and 6 check bits, there are 16 AND-gates to decode the 6 syndrome bits to determine the data bit in error. Table 1 shows the DP8400 matrix, called a Nelson Code, which has some unique features concerned with double soft error correction. For the purposes of this description, the matrix may be considered to be a form of Modified Hamming Code. The matrix has two functions: horizontally it tells us the value of the generated check bits for any data word when writing to memory, and vertically it tells us the syndrome word for any data bit in error. In a write cycle to memory, a '1' in any row indicates that the data bit in that column helps generate the parity bit in that row. For example, check bit 1 checks the parity of data bits 3, 6, 8, 9, 11, 13, 14 and 15, and generates even parity for those data bits. In a read cycle from memory, three or five of the six syndrome bits will go high for a single data bit error, and the columns represent the syndrome word, so the data bit in error is the number at the top of the column for that syndrome word. The 16 AND-gates each decode one of the 16 syndrome words shown in the columns of Table 1, to locate the error. If there is a data bit error, one of the outputs of the 16 AND-gates will go high, to complement the data bit in error.

If two errors have occurred, the syndrome word is simply the Exclusive-OR of the syndrome words of the two individual bits in error, whether data or check bits, and is always even parity. First, if two check bits are in error, the corresponding two syndrome bits will go high. Second, for one data bit and one check bit error, then either two, four or six syndrome bits will go high. Finally, if two data bits are in error, again two, four or six syndrome bits go high. Thus a parity check on the syndromes will indicate any two errors. This is important because if we know there are two errors, the DP8400 can attempt to correct them. The third error flag, E1, is the parity of the syndrome bus and check bit error. The DP8400 provides three error flags AE (Any Error), E0 and E1, as shown in Table 2, so that the exact nature of the error can be determined.

### Configuration and Control of the DP8400

The DP8400 has a 16-bit data I/O port and an 8-bit check bit I/O port (6 bits used with 16 data bits) for applications with memories used with 16-bit microprocessors. The 16-bit data I/O port sits on the memory data bus, and the 6 check bit I/O port connects directly to the check bit section of memory. In other words, each memory location now contains 16 data bits with 6 check bits. The DP8400 is expandable to beyond 80 data bits, each additional 16 data bits requiring an additional DP8400 without the need for extra logic circuitry. 32-bit wide memory busses are also a popular width for minicomputers. In addition, 16-bit microprocessor systems may use 32-bit memory, because this larger memory data width requires only 7 check bits, a lower percentage overhead of check bits to data bits.

Figures 2a and 2b show a simplified block diagram of the DP8400 with its control signals. The numerous control signals provide ease of use in the many varied applications of this chip. There are three latch enable signals DLE, CSLE and OLE. Whenever DLE is high, data on the data I/O port D0-15 is entered into the data input latch DIL, and is latched in as DLE goes low. This allows either processor or memory data to be present on the

data bus for only 3ns prior to, and held over for 10ns after DLE goes low. The data can then be removed if desired. Similarly, CSLE, when high, allows check bits on the check bit I/O port and external data on the syndrome I/O port to enter the check bit and syndrome input latches (CIL and SIL), respectively. These are latched in as CSLE goes low. (In 16-bit operation, OES, Output Enable Syndromes, will be set low permanently, inhibiting CSLE to SIL, which remains in the power-up reset condition so that it does not affect the simplified block diagram.) OLE, when set low, allows internal information into the data and check bit output latches (and the syndrome output latch, not shown). As OLE goes high, this information becomes latched. For some less complex designs, DLE, CSLE and OLE may be linked together. Providing OLE was low to allow corrected data into DOL, then OBO and OB1, when set low, enable the two data output buffers to present corrected data to the system. Data is enabled or disabled within 15ns of these inputs going low or high, respectively.

The DP8400 has three mode pins, M2, M1 and M0, which offer eight major modes of operation, designated 0 to 7. The most important two are Normal Write and Normal Read, and for these M1 and M0 are set low. M2 is READ/WRITE so Normal Write is mode 0 and Normal Read is mode 4. Other modes are used for the Double Complement Correct approach (Modes 1, 3 and 5) and for diagnostics (Modes 2 and 6). Mode 7 is used when expanded to more than 16 data bits and fast correction times are required.

### Normal Operation With a 16 Data Bit Memory

The basic requirements for normal operation of the DP8400 are that it generate check bits, detect errors and correct them with minimum delays, and that it be easy to use. In normal operation M1 and M0 are set low. Figure 2a shows how the DP8400 generates check bits when writing data to memory. DLE may be kept high, OLE low, CSLE low, and M2 low so that the DP8400 is in Mode 0. System data is presented to the data I/O port on pins D0-15, and enters DIL, where it connects to the check bit generator CG. The six generated check bits pass through COL and are enabled (with M2 low) onto the check bit I/O port. The six generated check bits will appear 30 ns after the 16 data bits are presented to the data I/O port. A write to memory will now store the 16 data bits and 6 corresponding check bits in the selected location of memory. The write cycle is therefore slowed down by 30ns, which in most memory systems is not significant.

Figure 2b shows the paths when reading from memory, with DLE set high to enter the memory data bits into DIL, and CSLE also set high to enter memory check bits into CIL. M2 is set high so that the DP8400 is in Mode 4. The Any Error flag, AE, becomes valid 35ns after memory data and check bits are valid. Error flags E1 and E0 become valid approximately 15ns later. Thus, if AE is low, no further operations are necessary. For fast 16-bit microprocessor systems, it may be necessary to introduce a wait state every read cycle to first determine if an error exists. If no error is detected the wait state is removed and the read cycle continues.

If an error is detected, then the error flags E1 and E0 must be examined to determine the required action. If

7

the error is a single data bit error, DOL will by now contain corrected data. If there is no check bit error, then COL, which follows CIL when in Mode 4, now contains the original check bits. By taking OLE high, corrected data bits are latched in DOL, and correct check bits in COL. The memory is now disabled, so that OBO and OB1 can be set low to enable corrected data onto the data bus, and M2 set low to enable the contents of COL onto the check bit bus. A write to the same location of memory will therefore remove the data bit error if it was a soft error. The microprocessor can read the corrected data once the wait signal is removed.

If the error is a single check bit error, DLE should be set low. DOL contains the contents of DIL, still correct data. Memory can now be disabled so that  $\overline{\text{OBO}}$  and  $\overline{\text{OBI}}$ , when set low, output correct data, and M2 when set low, allows the generated check bits from DIL to be output on the check bit I/O port. A write to the same location of memory will remove the check bit error if it was a soft error. The microprocessor now reads this correct data when the wait signal is removed. If a double bit error is detected, then other approaches may be taken, as described in the data sheet and later in this application note.

The primary features of the DP8400 are discussed in the data sheet; there are, however, a number of other features that become very useful once a designer becomes acquainted with error correcting techniques.

These include: expansion beyond 16 data bits, diagnostic routines, error logging (allowing some double error correction), and a novel approach offering fast correction of any double error. This application note discusses how the DP8400 has been designed to function in all of these applications, making it the most versatile and comprehensive error correction chip available.

### Error Checking and Correcting for Wider-Than-16-Bits Data Widths

At present, most 16-bit microprocessor systems use a 16-bit wide main memory, partly for simplicity, and also because main memories, in general, have not become large enough in size to justify otherwise. The data sheet shows how to accomplish this with one DP8400, utilizing the matrix of Table 1. It is fairly easy to use a memory of twice the microprocessor data width to reduce total chip count when incorporating error correction capability. One example would be a complex 8-bit microprocessor using large main memory. If the memory data width is kept at eight bits, then five check bits are required for error correction for each byte of data. If four banks of memory are required, each bank comprising 13 chips, then 52 total memory chips are required and only 62% of the memory is used for system data. If the memory data width is increased to 16 bits for the same microprocessor-based system, then six check bits are required.

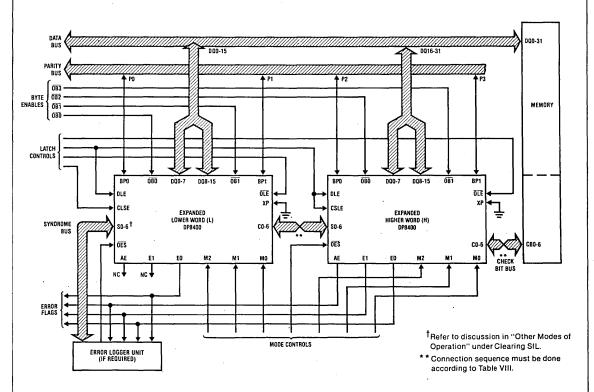


Figure 3. 32-Bit Error Detection and Correction

The memory now comprises two banks each of 22 chips, totaling 44 memory chips—a savings of eight memory chips. This saving is offset somewhat by the need to incorporate byte-writing capability, which does require extra components and slows down the memory write cycle. One DP8400 is still needed, using all 16 bits, and two bidirectional buffers are also required.

As a second example, using a 16-bit microprocessor with a memory of eight banks, each comprising 16 bits of data and six check bits, the total is  $8\times22$  or 176 memory chips. Once the memory is widened to 32 data bits with seven check bits, only four banks are required, and the total number of memory chips reduces to  $4\times39$ , or 156-a savings of 20 memory chips. This is offset a little by the fact that an extra DP8400 is required, and slightly slower memory write and read cycles are necessary. In some cases, therefore, widening the memory data bus becomes more practical for larger memories.

Saving memory chips is just one reason why there is a need to be able to expand the DP8400 beyond 16 data bits. Most minicomputers now use 32-bit wide data busses, and soon there will be some 32-bit microprocessors. Other systems use 24 bits, 48 bits, 52 bits, 64 bits or a variety of other data widths. The DP8400 has been configured to be expandable to any data width, even beyond 80 bits, merely by inserting an additional DP8400 for each 16-bit increment in memory data.

A section of the chip shown in the data sheet Block Diagram comprises the syndrome input and output latches, SIL and SOL, and a dedicated syndrome I/O port. This port has a number of uses not normally needed in simple 16-bit single error correction applications.

One use of this syndrome port is for data widths wider than 16 bits. Only one DP8400 is required with 16 data bits or less, but if a system uses more than 16 memory data bits, additional DP8400s are required. For example, two DP8400s, one with its 16-bit data port connected to the lower word, and the other to the higher word, can be configured to generate check bits, and detect and correct errors for a 32-bit memory as shown in Figure 3. For writing to memory, both chips will still generate six check bits from the two words of 16 bits. But with more than 26 total data bits, seven check bits are required. Therefore, it is necessary to combine the two sets of check bits to produce seven composite check bits to be written to memory as shown in the flow path depicted in Figure 4a. This is achieved by outputting the six generated check bits from the lower word DP8400 (designated L), and inputting them to H, the higher word DP8400. The syndrome port of H is available to receive these check bits from L, to be loaded into SIL of H, provided CSLE is high. The six outputs from SIL combine with the six check bits generated in H to create seven composite check bits, and this 7-bit combination is output on the check bit port to the memory check bits. Table 2 shows one of twelve possible ways to combine the two sets of check bits. Note that the lower word matrix for bits 0 and 15 is identical to Table 1 with the addition of all "0"s for the seventh check bit. The higher word matrix for bits 16 to 31 uses the same rows but in a different order, implying that the check bits from L must be cross-connected to H. For example, memory check bit 5 is generated from check bit 1 of L and check bit 5 of H. Both chips are therefore set to normal write mode when generating check bits.

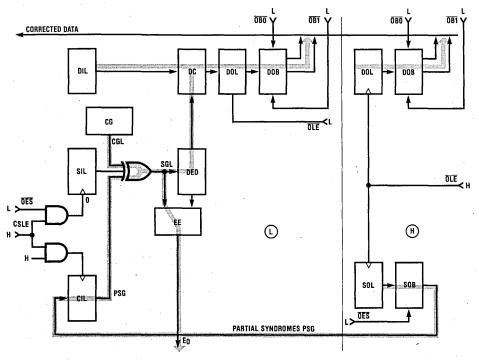


Figure 4a. E<sup>2</sup>C<sup>2</sup> 32-Bit Configuration, Error-Correct Flow Path

When reading from memory, the two chips first need to detect for an error. Figure 4b shows the flow path through the chips. L is set to normal write mode and H to normal read mode. Memory data is supplied to both chips so that L generates six check bits from the lower word data bits, and feeds them to SIL of H, the same as for writing. H also generates its own check bits which combine with those from L, and these seven composite check bits are compared with the seven memory check bits fed into CIL of H. This combining, plus comparison of check bits, is equivalent to seven 3-input Exclusive-OR gates. The output of these Exclusive-OR gates are the seven syndrome bits, and these can be decoded to determine the type of error. First, if there is no error, error flag AE of H will remain inactive because memory data is correct, provided OLE is kept low, and DOL of both L and H will contain correct data. Second, if there is a memory check bit error, only one of the seven syndromes will go high and the three error flags of H will indicate a check bit error as in Table 3. Note that memory data is still correct, and with OLE low, DOL of both L and H contain correct data. Third, if there is a single data error in bits 16-31, the syndromes of H are such that the data error locator will locate the error and correct it, so again DOL of both L and H contain correct data. This is because the seventh syndrome bit is low for an error in the higher word, so that we have a six syndrome bit word as in Table 1, to be decoded as normal to correct the error. In each of these three cases, DOL of both L and H contained correct data, and the common condition for these is either that AE(H) is "0", or E1(H) is "1".

The fourth case is more complex. In the previous three cases, correct data has been available in both DOL about 50 ns after memory data became valid. Now with a single data error in bits 0-15, AE(H) is a "1", EI(H) a "1", and EO(H) a "0", but L does not have sufficient information to locate the error. It is first necessary to feed back the partially generated syndromes of H back to L, and this is achieved by reversing the direction of the common bus. First L is placed in normal read mode so that L's generated check bits become disabled. Next, the partial syndromes in H are enabled onto the bus by setting OES of H low, so that its syndrome I/O port outputs the combined Exclusive-OR of CG(H) and CIL(H), which is transferred to CIL of L. These partial syndromes then combine with CG(L) to generate valid syndrome bits in L, demonstrated by the flow path of Figure 4c. If there is, in fact, a data bit error in bits 0-15, the seventh syndrome bit will go low, allowing the remaining six bits to be decoded to locate the error as per the columns of Table 2. This switching around of the common bus, therefore, takes more time to correct the error in L, equivalent to a total time of approximately 100 ns. The fifth kind of error is identified as a double error. In this case, the error flags indicate the double error and the system can take the necessary action.

A logical approach when using two DP8400s would be to first see if there is any need to reverse the common bus by monitoring AE(H), and when it is low, to output directly from DOL of both chips by setting OBO and OB1 of each low. The System Data Valid flag should be set active at this time. If the AE(H) output is high and the error flags do not indicate a double error, then the common bus should be switched around and the System Data Valid signal set true. If the error is a double error, the user may utilize a number of alternatives, including the Double Complement Correct method.

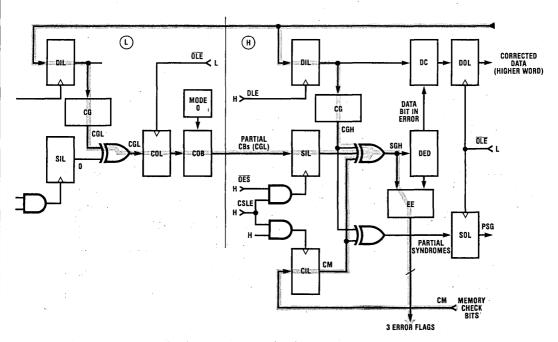


Figure 4b. E<sup>2</sup>C<sup>2</sup> 32-Bit Configuration, Detect Flow Path

Table 1. Data in to Check Bit Generate, or Data Bit Error to Syndrome-Generate Matrix (16-Bit Configuration)

		0	1	2	3	4	5	6	7		9	.1	1	1 2	1	1	1 5		DQ0-15
		GENE	RATI	E CH	ECK	BITS	_		·	-	•				_	•			
	0	0	0	1	1	1	1	1	1	0	1	1	1	0	1	1	1	0	
	1	0	0	0	1	0	0	1	0	1	1	0	1	0	1	1	1	1	
CENEDATED	2	1	0	0	. 1	1	0	0	0	1	0	1	0	1	1	1	1	2*	CENEDATED
GENERATED SYNDROMES	3	0	1	1	Ó	0	0	0	1	1	1	1	0	1	0	1	. 1	3*	GENERATED CHECK BITS
OTTOMES	4	1	1	0	0	0	1	0	_1	1	0	0	1	0	1	0	1	4	OTILOR BITO
	5	1	1	1	0	1	1	1	0	1	0	0	0	1	1	1	0	5	
		4	8	9	7	5	1	3	9	E	В	D	3	С	7	F	F	0	
		3	3	2	0	2	3	2	1	3	0	0	1	2	3	2	1	1	

HEXADECIMAL EQUIVALENT OF SYNDROME BITS

\*C2, C3 generate odd parity.

Table 2. Data Bit Error to Syndrome-Generate Matrix (32-Bit Configuration)

· .				1						L															H	4									
												٦	1	1	1	1	1	1	1	1	1	2	2	2	2	2	2	2	2	2	2	3	3		DQ0-31
		0	1	2	3	4	5	6	7	8	9	0	1	2	3	4	5	6	7	8	9	0	1	2	3	4	5	6	7	8	9	0	1		DQ0-31
4. 4	0	0	0	1	1	1	1	1	1	0	1	1	1	0	1	1	1	0	0	0	1	0	0	1	0	1	1	0	1	0	1	1	1	- 1	
	1	0	0	0	1	0	0	1	0	1	1	0	1	0	1	1	1	1	1	1	0	1,	1	1	0	1	0	0	0	1	1	1	0	5	•
•	*2	1	0	0	1	1	0	0	0	1	0	1	0	1	1	1	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	6	OCNEDATED
SYNDROMES	*3	0	1	1	0	0	0	0	1	1	1	1	0	1	0	1	1	0	1	1	0	0	0	0	1	1	1	1	0	1	0	1	1	3	GENERATED CHECK BITS
	4	1	1	0	0	0	1	0	1	1	0	0	1	0	1	0	1	1	1	0	0	0	1	0	1	1	0	0	1	0	. 1	0	1	4	ON LON BITO
	5	1	1	1	0	1	1	1	0	1	0	0	0	1	1	1	0	1	0	0	1	1	Ó	0	0	1	0	1	0	1	1	1	1	2	
	6	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	.1	1	1	1	1	1	0	1	1	1	0	1	1	1	0	
		4	8	9	7	5	1	3	9	E	В	D	3	С	7	F	F	2	Α	Α	1	2	2	3	8	В	9	8	1	Α	3	В	9	0	HEX
		3	3	2	0	2	3	2	1	3	0	0	1	2	3	2	- 1	3	1	4	6	6	5	4	5	3	4	6	5	2	7	6	7	1	

\*CG2, CG3 generate odd parity.

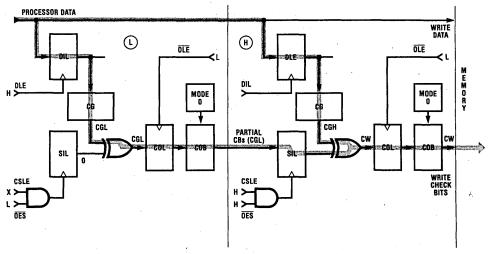


Figure 4c. E<sup>2</sup>C<sup>2</sup> 32-Bit Configuration, Write Flow Path

Table 3. Error Flags After Normal Read (32-Bit Configuration)

AE (H)	E1 (H)	E0 (H)	E0 (L)*	Error Type
0	0	0	0	No error
1	1	0	0	Single check bit error
1	1	1	0	Single data bit error (H)
1	1	0	1	Single data bit error (L)
1	, 0	0	0	Double bit error
	All O	thers		Invalid conditions

<sup>\*</sup>E0 (L) is valid after transfer of partial syndromes from higher to lower.

This approach to wider data width error detection and correction is termed the cascade configuration, and it requires only the one additional DP8400. The cascade approach can be used with up to five DP8400s controlling 80 data bits. The advantage is that only one additional DP8400 is required per 16 data bits, although write and read times become progressively slower as the number of DP8400s is increased. This is because of the time taken for the generated check bits to ripple through from the lowest to highest chips when writing and detecting, and then ripple back the other way for correcting.

In many memory systems, speed is of utmost importance and for faster systems, it is possible to connect the DP8400s in a parallel configuration using additional ICs. Application Note AN-308 describes this approach in detail.

The user may, therefore, select one of these approaches (or a combination of both) for systems using memory data widths of more than 16 bits.

### Diagnostic Capabilities of the DP8400

The DP8400 has been designed with system fault diagnosis in mind. In fact, it is possible under microprocessor control with the DP8400 in situ on the memory board to fully test every gate inside the DP8400 activated in normal operation, and also to diagnose all memory check bits. The DP8400 has two main diagnostic modes — modes 2 and 6. In other words, with M1 set high and M0 set low, information can be written to or read from the chip.

Mode 6 allows the memory check bits to be read onto the higher byte bits 8–14, and syndromes to be read on the lower byte bits 0–6, as shown in Figure 5a. The remaining two bits, 7 and 15, are the error flags E1 and E0 that were valid when mode 6 was entered. The syndrome bits will be the internally generated syndromes if OES is low (mode 6A), or external syndromes input on the syndrome I/O port if OES is high (mode 6B). The external syndromes could be obtained from an error logger/syndrome injector unit—this is an error logger with the capability of injecting syndromes back to the DP8400. Therefore, by being able to read the externally stored syndromes, the microprocessor can monitor or store the syndromes whenever needed.

Mode 2 transfers system data from the higher byte into CIL, instead of DIL, to simulate check bits. This can be used in three ways. First, as shown in *Figure 5b*, the simulated check bits can be latched in CIL by taking CSLE low. If the DP8400 is now set to normal read, mode 4, and new data is presented then, provided DLE is high

and CSLE is kept low, the DP8400 will perform a normal read operation as if it were reading memory check bits. The results of this simulated read may be checked by enabling DOL to see if an error (if inserted) was corrected. Or as a further check, by entering mode 6, the predicted generated syndromes and error flags may be checked. Second, also while in mode 2, the simulated check bits appear at the check bit port (from the data bus higher byte) available to be written to the check bit portion of memory as shown in Figure 4c. OLE is set high before the original simulated check bits are removed and then memory data is subsequently placed on the data bus. A write to memory will now write known data and simulated check bits to the selected location. By writing known data to the memory check bits in mode 2, and then reading the memory check bits in mode 6, each check bit in each location can be validated. Third, it is possible in mode 2 with OES low to transfer data from the higher byte to the syndrome I/O port, also shown in Figure 5c. But first the generated check bits must be all low. This is attained by previously loading all "1"s into DIL in an earlier cycle. This is useful when using an error logger in conjunction with the DP8400 to feed the syndrome word into the logger whenever an error occurs.

# Error Logging with Syndrome Injection Capability

An important application of the dedicated syndrome I/O port is for error logging. This is because the internally generated syndromes derived during reading are available on this port, provided OES is set low. These syndromes indicate the exact location of a single error, whether it is in the data bits or check bits; they are therefore useful to be stored for error logging. Every time an error occurs when indicated by error flag AE, the syndromes corresponding to this error can be logged.

The syndrome word can be fed from SOL via the Syndrome Output Buffer onto the external syndrome bus. An Error Logger connected to this bus, as shown in Figure 6, will store the syndrome word in the same location as the corresponding address of each error that occurs. An intelligent error logger will differentiate between new errors and ones that have occurred previously, by logging only new errors and ignoring ones that have already occurred. An easy way to determine this would be to compare the incoming memory address with the address of errors contained in the logger. If a match is not found and an error occurs, the new address and corresponding syndromes are logged. If a match is

found, then whether an error occurs or not, no further action is necessary. Tag bits may be provided to indicate whether the error is hard or soft.

For example, if an error has already been logged at a particular address and that address is re-written to, then if the error repeats subsequently, it is a hard error, and if not, it is a soft error. So, if a tag bit is set when a write occurs to a previously logged address and a subsequent error is detected at that address, a second tag bit is set indicating a hard error. A better approach would be to have the DP8400 correct and rewrite to the same location all in the same cycle, as soon as a single error is detected. The first error detected in a location is classified as a soft error until it recurs, and if an error does recur, a tag bit is set to indicate a hard error. It is assumed here that multiple soft errors will not occur in the same location.

Now that the error logger contains error information, it is necessary for the microprocessor to retrieve it. The DP8400 makes this easy, because the external syndrome bus data can be transferred to the data bus as described for operation in mode 6. If the error logger is made capable of outputting stored syndromes, and subsequently outputting the corresponding address one byte at a time, then all the relevant information can be retrieved by the microprocessor. The user may choose to store this in nonvolatile memory in the event of a power failure. When power returns, it will be desirable to restore this information back to the error logger, and this can be achieved by first loading DIL with all "1"s to create all generated check bits low. Now the addresses and syndromes can be loaded from the higher byte of the microprocessor through the syndrome I/O port one byte at a time, with DP8400 in mode 2, to the error logger.

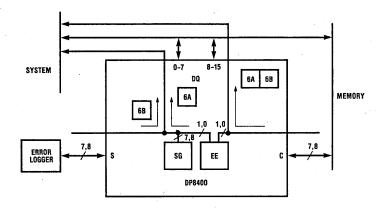


Figure 5a. Read Internal Generated Syndromes and Check Bit Port (Mode 6A) or Read Syndrome Port and Check Bit Port (Mode 6B)

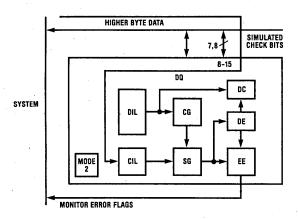
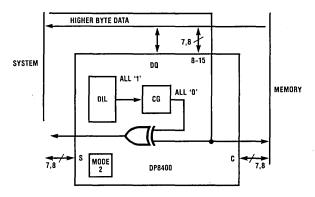


Figure 5b. Diagnostic Read — Compare Simulated Check Bits with Check Bits Generated from Data Stored in Previous Cycle



- 1) DIAGNOSTIC WRITE: WRITE HIGHER DATA BYTE TO CHECK BIT BUS (MODE 2)
- 2) TRANSFER HIGHER DATA BYTE TO SYNDROME BUS (MODE 2, PREVIOUS CYCLE LATCHED ALL '1's IN DIL TO MAKE CG=0)



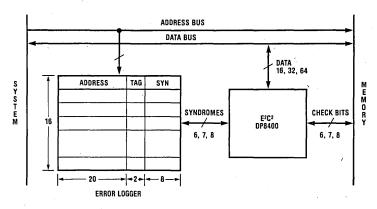


Figure 6. Error Logger Connected to DP8400 Syndrome Port

### Correcting Double Errors Using the Error Logger

It is possible to take the error logging function one stage further. As described so far, the error logger has been storing single errors (data bit or check bit). What if a double error is detected? If it is detected without any previous history at that address, one solution would be to perform a Double Complement to attempt to correct both errors. If this is not done, no useful information can be obtained. If both errors are corrected, the error logger records the syndromes of both, and tags whether they were both hard, or one hard and one soft. But, if there is a previous history at this address of a single error, then it is fair to assume that the second error has subsequently occurred. In this case, if the error logger could be made to inject the syndromes of the first error into the DP8400. the DP8400 would correct this error so that its DOL would then contain data with one error (if both errors are data bit errors). It is necessary at this point to wraparound DOL back to DIL and allow the DP8400 to correct the second error. This approach is much faster than the Double Complement approach and at the same time offers full error logging capability.

# Any Double Error Correction Using The Double Syndrome Decode Approach

The data sheet shows how the DP8400 can perform double error correction using the Double Complement Approach, provided at least one of the errors was hard. For very large memories, this may not be adequate, as some systems will require total double error correction capability - quickly, without having to wait two additional memory cycles. Some of these systems will also required triple error detect capability. Fortunately, the matrix of the DP8400 has been configured to allow both of these capabilities. Most modern error detection/ correction matrices use a modified version of Hamming's original code. The Hamming code allows single errors to be corrected, however, two errors may not be detected as such. For 16 data bits, five check bits are required. Modified Hamming codes allow double error detect capability, as well, by arranging that the Exclusive-OR of the syndrome words of any two bits in error produces an even parity syndrome word. A parity check on the syndrome bus will, therefore, indicate two errors (or no error, but in this case, the Any Error flag will be inactive). For 16 data bits, six check bits are required for single/double error detect and single error correction capabilities.



The DP8400 has a matrix that goes one step further by using a version of the Nelson code. This costs no additional on-chip gates to those required for a Modified Hamming code. To be able to correct any two errors, it is necessary to be able to determine their location, and no present version of the Modified Hamming code is able to do this. There are matrices that do exist that can generate 12 check bits from 16 data bits (or 14 check bits from 32 data bits) for writing, and then generate 12 (or 14) syndrome bits when reading, so that the location of both errors can be determined and corrected. But, because most applications do not require this degree of integrity and associated expense, they are not very popular. It would be ideal if two DP8400s could be configured as in Figure 7a, with each generating a different set of check bits and a different set of syndrome bits so that the double syndrome word could be unique and decodable for any two bits in error. Fortunately, National Semiconductor has achieved this by incorporating a feature called the Rotational Syndrome Word Generator, which uses rotated data to the secondary DP8400.

The primary DP8400 generates check bits when writing, and syndrome bits when reading, as in a normal 16-bit system. But the data port of the secondary DP8400 receives data shifted by a number of bits, usually one bit. In other words, for this secondary chip, system data bit 0 connects to DQ1, system data bit 1 to DQ2, etc. Each DP8400 has its own dedicated six memory check bits, which are obviously different from each other due to the data shifting on the secondary DP8400. The Nelson code is such that during a read, not only does each DP8400 generate a different set of syndrome bits, but the double syndrome word (comprising 12 bits for 16 data bits) is unique for any two bits in error. It is necessary to be able to output these syndromes as they occur and to do this, OES of both chips is set low during the time memory data is valid.

Now that we have a unique double syndrome word for any two bits in error, it is necessary to decode it to correct both errors. The easiest way to do this is to connect the double syndrome word to the address inputs of a registered PROM (a PROM with latchable data out) as shown in Figure 7b. In this example, 12 syndrome bits require 4k addressing capability, and 32k registered PROMs will be made available soon. Some of the addresses of the RPROM will be used for double errors and each address will be unique for any two bits in error. The

SYSTEM

DATA

DATA

MEMORY

CP

SECONDARY

SS

SP

Figure 7a. 2 Different Generators

corresponding data out could, therefore, contain one of the syndrome words. Double errors may be caused by two data bit errors, a data bit and primary check bit error, a data bit and secondary check bit error, a primary and secondary check bit error, or two errors in either primary or secondary check bits. In these cases, if the RPROM address stores the syndrome word for one of the two errors, this will be available at the output of the RPROM when enabled.

First of all, this data must be latched in the RPROM register, and then the OES input to each DP8400 must be set high to deactivate the two syndrome output buffers. Next, the RPROM data must be enabled onto the primary syndrome bus so the primary DP8400 can enter this syndrome word, representing one of the two bits in error with CSLE high. At the same time, the primary DP8400 must be set to mode 7 so that the syndrome word appears on the internal syndrome bus, replacing the generated syndromes. If OLE is now set from low to high, DOL will contain either one or no error, depending on where the two errors were located. In other words, the DP8400 has just corrected one of the errors. By setting OLE low, then disabling memory and enabling OBO and OBI of the primary DP8400, this data is output on the data bus and back into the DIL with DLE high. There is now only one data error, and this can be corrected by setting the DP8400 to normal read, mode 4.

Thus, both errors have been corrected at a fairly fast rate. For example, for a 50 ns RPROM, the total time to generate double syndromes, feed back a one-error syndrome word to the primary DP8400, correct it, wraparound, and correct again, may take less than 120 ns total.

Only a few of the addresses in the RPROM are required for double errors. Some double syndrome words represent single errors and triple errors. All single bit errors also produce a unique double syndrome word different from all double bit errors.

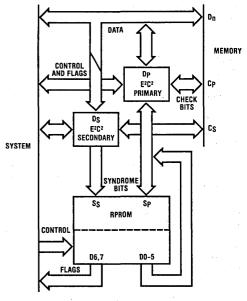


Figure 7b

7

In fact, nearly all triple bit errors produce unique double syndrome words different from single and double bit errors. Those that do not produce unique double syndrome words, duplicate double syndrome words of other single. double, and triple bit errors; however, these comprise only about 5 percent of the total. We can say, therefore, that this approach will correct not only all double bit errors, but will detect 95 percent of all triple bit errors. Note that with error correction systems utilizing the modified Hamming code, the majority of triple bit errors are interpreted as single bit errors and falsely corrected as such. It is up to the designer to determine the chances of three errors occurring in a memory location, and the (likely) consequences that they will be falsely corrected. If this condition is undesirable, then the Double Syndrome Decode Method offers greatly enhanced integrity; in fact, if the three errors detected do have a unique double syndrome word, they can be corrected. As stated, no presently used Modified Hamming code offers a unique double syndrome word for multiple errors; this is only possible with a Nelson code. This example was largely for 16 data bits, but the idea will work for other data widths.

In the 16-bit example, the RPROM has to output only six bits representing the syndrome bits of a bit in error. This leaves two spare bits which can be used as flags, and the user can program his RPROM accordingly. One solution is to use these flags to indicate the type of action required — whether to correct at all, correct once, or correct twice by wrapping around.

### **Block Diagram of the DP8400**

This Application Note discusses first the single error correction, showing a simplified block diagram of the chip for both a write cycle to generate check bits, and a read cycle to detect errors and correct single bit errors.

The most important requirement when accessing memory is that these operations be performed with minimal memory delays. The DP8400, therefore, has been structured Internally to minimize series propagation delays through the chip. A full block diagram of the DP8400 is shown, and first impressions are that there might be excessive delays in the various paths due to the additional blocks that have been added to the basic functional block diagram. In fact, this is not the case, because the DP8400 has been configured in bipolar Schottky logic and uses the AND-OR-INVERT gate in many of the blocks. This type of gate structure is used in multiplexers, Exclusive-OR gates and fall-through latches. It is possible, therefore, to combine these functions into one wide gate, reducing the propagation delays through some of these blocks to that of one gate. For example, the check bit output latch COL receives its input from an Exclusive-OR gate followed by a multiplexer. These three functions can be combined into one wide gate, and this greatly reduces the time taken to generate check bits.

### The DP8400 — A Versatile Error Checker/ Corrector for All Applications

It was shown earlier how the DP8400 was able to detect single and double errors, and correct single errors. For 8-and 16-bit systems, these could easily be accomplished with a minimum of extra circuitry. The DP8400 can also be used in complex high integrity systems. In fact, investigations are still progressing as to its immense capabilities. It is the only error correction circuit capable of these features, and yet it still provides very fast throughput. For these reasons, the DP8400 should become the industry standard error correction chip for the foreseeable future.

### **DP8400s in 64-Bit Expansion**

National Semiconductor Application Note AN-308 Chuck Pham June 1982



The purpose of this Application Note is to provide memory designers with detailed information on the DP8400 parallel expansion method. This method allows fast check bit generation, error detection, and error correction. A thorough understanding of the 16-bit implementation is a prerequisite. Included in this note are the following: error correction expansion matrix; detailed steps for check bit generation, error detection and error correction; an example of a single error correction; and the detailed wiring diagram for the 64-bit configuration.

### The Error Correction Expansion Matrix

For a 16-bit word, the DP8400 reads data between the processor and memory, with its 16-bit bidirectional data bus connected to the memory data bus. The DP8400 uses an encoding matrix to generate six check bits from the 16 bits of data. This 16-bit matrix contains 16 unique syndrome patterns corresponding to each error location which allows the DP8400's Data Error Decoder (DED) to identify the data error location.

The DP8400 is easily expandable to other data configurations. For a 32-bit data word with seven check bits, two DP8400s are used. Three DP8400s can be used for 48 bits, four DP8400s for 64 bits, and five DP8400s for 80 bits, all with eight check bits. In order to expand the DP8400, additional check bits are required to provide the unique characteristic of the single data error syndrome. For expansion beyond 24 bits, check bits 6 and 7 (C6 and C7) are used. Note that these check bits can be configured to be always either zero or word parity, depending on the input voltage level of the Expansion Pin (XP). By rearranging all eight check bits (C0- C7) of each DP8400, we can obtain many different matrices that meet the above requirement. One of these is shown in Table 1. For illustration, this matrix will be used throughout this application note to clarify the E2C2 expansion concept.

### Check Bit Generation, Error Detection And Error Correction

### Check Bit Generation (Figure 1)

In the Check Bit Generation mode, all four DP8400s are set to mode 0, normal write. The 64 bits of data from the system data bus are enabled into the Data Input Latches (DIL) of each DP8400. The individual Check Bit Generators (CG) of the four DP8400s then produce eight parity bits, or partial check bits, derived from the input data. (Note that all the syndrome input latches should be cleared so that only the partial check bits will pass through the Check Bit Output Latches/Buffers (COL and COB)). In the normal write mode, the COBs are always enabled onto each check bit port. This allows the partial

Table 1. Data Bit Error to Syndrome-Generate Matrix, 64-Bit Configuration

The partial code of device 0:

Error Locations (Data Bit Numbers)

0	1	2	.3	4	5	6	7	8	9	10	11	12	13	14	15	
0	0	1	1	1	1	1	1	0	1	1	1	0	1	1	1	C0
0	0	0	1	0	0	1	0	1	1	0	1	0	1	1	1	C1
1	0	0	11	1	0	0	0	1.	0	1	0	1	1	1	1	C2
0	1	1	0	0	0	0	1	1	1	1	0	1	0	1	1	C3
1	1	0	0	0	1	0	1	1	0	0	1	0	1	0	1	C4
1	1	. 1	0	1	1	.1	0	1	0	0	0	1	1	1	0	C5
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	C6
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	C7_

The partial code of device 1:

16	17	18	19	20	21	22	23	24	25	26	27	28	29	30	31	
0	0	0	1	0	0	1	0	1	1	0	1	0	.1	1	1	C1
1	1	1	0	1	1	1	0	1	0	0	0	1	1.	1	0	C5
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	C6
1	1	0	0	0	1	0	1	1	0	0	1	0	1	0	1	C4
0	1	1	0	0	0	0	1	1	1	1	0	1	0	1	1	СЗ
1	0	0	1	1	0	0	0	1	0	1	0	1	1	1	1	C2
0	0	1	1	1	1	1	1	0	1	1	1	0	1	1	1	C0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	C7

The partial code of device 2:

32	33	34	35	36	37	38	39	40	41	42	43	44	45	46	47	
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	C6
0	1	1	0	0	0	0	1	1	1	1	0	1	0	1	1	СЗ
1	1	1	0	1	1	1	0	1	0	0	0	1	1	1	0	C5
1	1	0	0	0	1	0	1	1	0	0	1	0	1	0	1	C4
1	0	0	1	1	0	0	0	1	0	1	0	1	1	1	1	C2
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	C7
0	0	0	1	0	0	1	0	1	1	0	1	0	1	1	1	C1
0	0	1	1	1.	1	1	1	0	1	1	1	0	1	1	1	C0

The partial code of device 3:

48	49	50	51	52	53	54	55	56	57	58	59	60	61	62	63	
1	1	0	0	0	1	0	1	1	0	0	1	0	1	0	1	C4
1	1	1	0	1	1	1	0	1	0	0	0	1	1	1	Ó	C5
0	1	1	0	0	0	0	1	1	1	1	0	1	0	1	1	C3
1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	C6
1	0	0	1	1	0	0	0	1	0	1	0	1	1	1	1	C2
0	0	1	1	1	1	1	1	0	1	1	1	0	1	1	1	C0
0	.0	0	1	0	0	1	0	1	1	0	1	0	1.	1	1	C1
1	1	1	1	1	1	1	1	. 1	1	1	1	1	1	1	1	C7

check bits to be combined externally in the eight 74S280s' parity generators/checkers to produce eight composite check bits. Table 2 shows how these check bits are generated.

Table 2. Composite Check Bit Generation

Ccomp. 0	=	C(0)0	<b>⊕</b>	C(1)1	<b>⊕</b>	C(2)6	<b>⊕</b>	C(3)4	
Ccomp. 1	=	C(0)1	$\oplus$	C(1)5	$\oplus$	C(2)3	$\oplus$	C(3)5	
Ccomp. 2	=	C(0)2	$\oplus$	C(1)6	$\oplus$	C(2)5	$\oplus$	C(3)3	
Ccomp. 3	=	C(0)3	$\oplus$	C(1)4	$\oplus$	C(2)4	$\oplus$	C(3)6	
Ccomp. 4	=	C(0)4	$\oplus$	C(1)3	$\oplus$	C(2)2	$\oplus$	C(3)2	
Ccomp. 5	=	C(0)5	<b>⊕</b>	C(1)2	$\oplus$	C(2)7	$\oplus$	C(3)0	
Ccomp. 6	=	C(0)6	<b>⊕</b>	C(1)0	Ф	C(2)1	$\oplus$	C(3)1	
Ccomp. 7	=	C(0)7	æ	C(1)7	Œ)	C(2)0	æ	C(3)7	

#### Notes:

Ccomp: composite check bit.

C(X)N: the partial check bit N of device X.

(Refer to Table 1 for clarification.)

To aid in fast error detection during memory read cycles, these composite check bits are complemented and written into memory along with the system data. If the system data has vacated the data bus, the Output Enables (OBO and OB1) must be set low so that the original data word with its eight composite check bits can be written into memory.

### **Detection Mode (Figure 2)**

In the Detection mode, again all the DP8400s are set to mode 0, normal write, then the partial check bits derived from the memory data bits are generated in a manner similar to that described for the check bit generation mode. These partial check bits are then associatively compared with the memory check bits in the eight 74S280s to produce eight external Composite Syndrome bits. As explained in the check bit generation mode, the composite check bits are complemented before being written into memory. This shows why complemented Composite Syndrome bits are produced instead of true composite syndromes. Then, if any bits on the Composite Syndrome bus go low, this will cause the 74S30 NAND gate to go high, giving the Any Error indication. If there is no error, all Composite Syndrome bits remain high. These Syndrome bits are also latched into the 74ALS533 Octal D-type Transparent Latch (with inverted output). The composite syndromes are then fed into the syndrome ports of the DP8400s in different combinations for each, for error-type determination and/or error correction.

### Correction Mode: (Figure 3)

Upon receiving the Any Error indication during the detection mode, it takes an additional step to determine the error type and to correct a single data error. All the DP8400s should be set to mode 7B (which is mode 7 with OES high), this mode enables the external syndromes directly to the Syndrome Generator (SG) and then the Data Error Decoder (DED) of each chip. For a single data error, the input syndrome will be unique for that error location; consequently, only one DP8400 can decode that error location and correct that bit. The other three do not indicate an error and do not change their data output latch contents. This corrected data can be output to the system data bus by means of OB0 and OB1. The DP8400 that decodes the data error location will indicate a single data error, while all others indicate a check bit

error. If there was a single check bit error or a double bit error, then all the DP8400s will indicate a check bit error or a double bit error, respectively, through their error flags.

### An Example of a Single Data Error Correction

Assuming all zero data is to be written into memory, we obtain the following set of partial check bits for all DP8400s:

$$\begin{array}{lllll} C0 = 0 & C4 = 0 \\ C1 = 0 & C5 = 0 \\ C2 = 1 & C6 = 0 \\ C3 = 1 & C7 = 0 \end{array}$$

Note that each DP8400 contains the basic 16-bit matrix (C0-C5). Therefore, the first six partial check bits are the same for all devices; only C6 and C7 are different. With the 64-bit configuration using the above 64-bit matrix, C6 = C7 = 0 (by connecting XP directly to  $V_{CC}$ ) for the devices 0, 1, and 2; and C6 = C7 = word parity (by leaving XP pin floating) for the device 3. However, with all zero data, word parity is also zero (even parity). Therefore, the above partial check bits are obtained.

Using the formulas given in Table 2, the composite check bits are as follows:

Ccomp. 
$$0 = 0 \oplus 0 \oplus 0 \oplus 0 \oplus 0 = 0$$
  
Ccomp.  $1 = 0 \oplus 0 \oplus 1 \oplus 0 = 1$   
Ccomp.  $2 = 1 \oplus 0 \oplus 0 \oplus 0 \oplus 1 = 0$   
Ccomp.  $3 = 1 \oplus 0 \oplus 0 \oplus 0 \oplus 0 = 1$   
Ccomp.  $4 = 0 \oplus 1 \oplus 1 \oplus 1 \oplus 1 = 1$   
Ccomp.  $5 = 0 \oplus 1 \oplus 0 \oplus 0 \oplus 0 = 1$   
Ccomp.  $6 = 0 \oplus 0 \oplus 0 \oplus 0 \oplus 0 = 0$   
Ccomp.  $7 = 0 \oplus 0 \oplus 0 \oplus 0 = 0$ 

Note that these composite check bits are complemented before they are written into memory. Thus, the memory check bits read later from memory are 1100 0101.

If an error has occurred in the data position 35 which is bit 3 of device 2, then the partial check bits C(3)N produced during the detection mode are as follows:

C(3)0 = 1	C(4) = 0
C(3)1 = 1	C(5) = 0
C(3)2 = 0	C(6) = 0
C(3)3 = 1	C(7) = 0

The partial check bits of other devices are unchanged. Consequently, the newly generated composite check bits (Ccomp) and the total syndrome bits are:

Bit #	Newly General Composite Check Bits	ed	Memory Check Bits		Composite Syndrome
.0	0	<b>⊕</b>	1.	=	1
1	. 1	$\oplus$	0	=	1
2	0	$\oplus$	1	=	.1
3	1	$\widetilde{\oplus}$	0	=	1
4	0 .	$\oplus$	0	=	0
5	1	$\oplus$	. 0	=	1
6	1	$\oplus$	1	=	0 .
7	1	$\oplus$	1	=	0

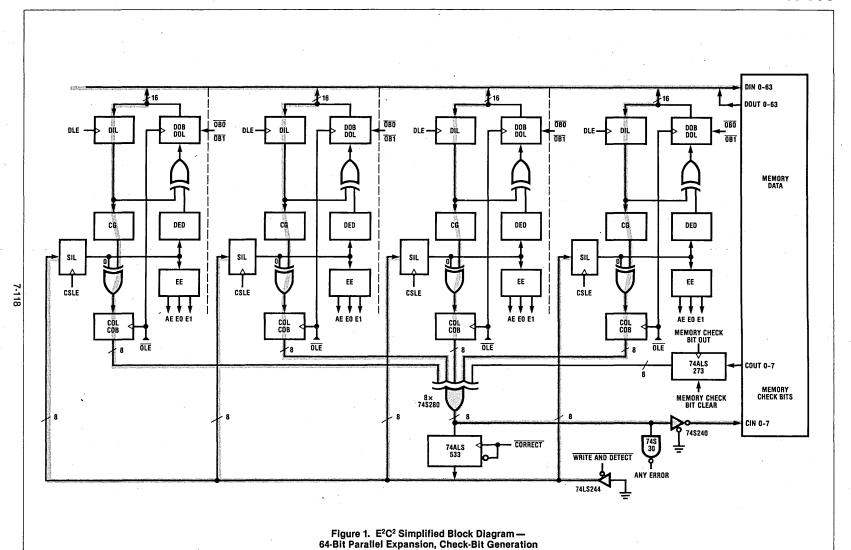
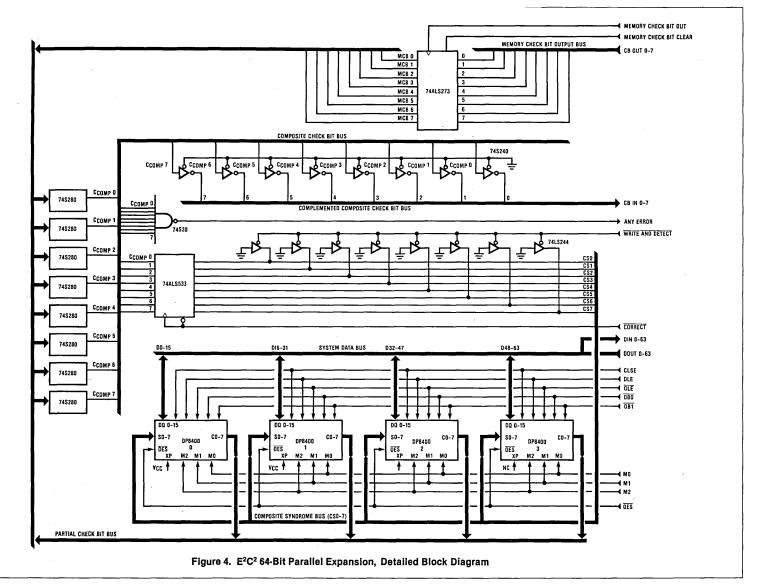
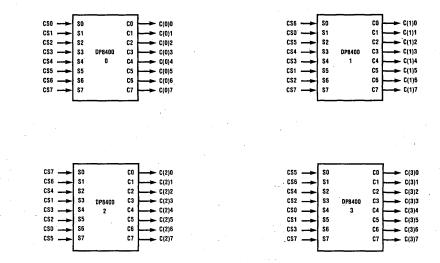


Figure 3. E<sup>2</sup>C<sup>2</sup> Simplified Block Diagram — 64-Bit Parallel Expansion, Error Determination and Correction







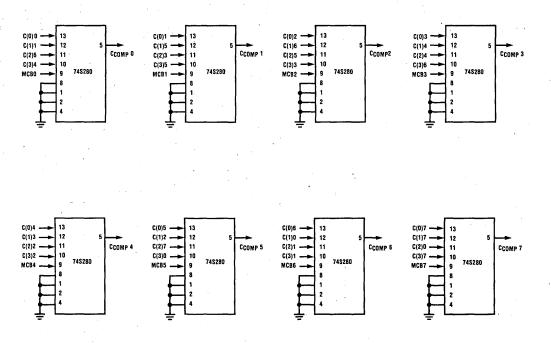


Figure 5. E<sup>2</sup>C<sup>2</sup> 64-Bit Parallel Expansion, Detailed Connection Diagram

The composite syndrome 1101 0000 is that of the error location 35. Since the syndrome is unique and fed reordered to each DP8400, only device 2 will recognize this syndrome pattern and complement its data bit 3. Then the corrected data can be output to the system data bus when  $\overline{OB0}$  and  $\overline{OB1}$  of all four DP8400s go low. Devices 0,

1, and 3 all output the same data they received from memory. Only device 2 changes its (erroneous) data. Refer to *Figure 6* below for the timing diagrams of a memory write and memory read cycle (detect then correct):

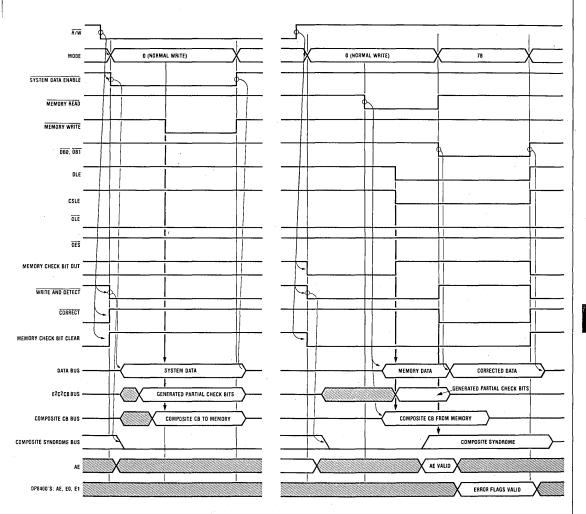


Figure 6A. E<sup>2</sup>C<sup>2</sup> 64-Bit Parallel Expansion Memory Write Cycle

Figure 6B. E<sup>2</sup>C<sup>2</sup> 64-Bit Parallel Expansion Memory Read Cycle (Detect Then Correct)



SYSTEM DESIGN/WEMORY SYSTEMS

# ERROR CORRECTION THE HARD WAY

A double complement correct cycle in an ECC system forms a sophisticated double-bit error correction and management system

# by Bob Nelson

The use of parity, the most common error detection method, can be expanded from simple error detection in data words to the correction of single-bit errors by means of a double complement correct cycle. The double complement method can also be used to advantage in combination with error checking and correction systems to detect and correct hard and soft combinations of double-bit errors, provided no more than one of such errors is soft. In addition, this technique points the way to more sophisticated double-bit error correction and error management systems.

A parity bit is assigned a value of 1 or 0 on the basis of the number of 1s in the data word. The value of the parity bit depends on whether the parity system chosen is odd or even. Thus, in an odd parity system, the sum of the 1s in the data word and the parity bit will always be odd, whereas in an even parity system, the sum of the 1s in the data word and the parity bit will always be even (Fig 1). All examples in this discussion, except for those in Fig 1, use odd parity. A single parity bit can be used to detect a single-bit error occurring during a memory read cycle, and the technique can be expanded to provide even further error handling.

### Parity error detection and correction

During a memory write, the parity bit which is created as a result of the data is written to the memory along with the data word for storage. When a read cycle occurs, parity generation is again performed on the data word, creating a new parity bit, which is then compared with the original parity bit read from memory. If a difference exists between the two parity bits, an error has occurred. Although this error cannot be located with the information given, and may have occurred in any bit lo-

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Data Word	Parity	Number of 1s	System
10001010	1	4	even
10001010	0	3	odd
01101001	1	5	odd

Fig 1 Odd and even parity. Value of parity bit is generated to satisfy chosen parity system (even or odd) so that sum of all 1s, including parity bit, will conform to even or odd parity system

cation in the data word or even in the parity bit, if it is a hard error, its location can be determined through the use of additional memory cycles.

If an error is detected during a memory read cycle, a simple procedure called the double complement method will determine if the error is hard, and, if so, correct it. The method includes a routine during which the suspect data and parity bit are complemented and presented to the same location in memory for a write cycle. Following the write, a read cycle is performed, and if the error is a hard error, the memory will repeat it by providing the data with the error bit complemented again. After a second complement, the data will be correct. At the end of such a correct cycle the memory contains the complemented data, and one additional write cycle must be performed to restore the data in memory (Fig 2).

During a double complement correct cycle involving a data word containing an even number of bit locations, the parity test is performed after the second read and before the second complement. If the error is hard, a parity error will once again be detected following the second read. If the error is soft, a parity error will not result following the second read. For data words containing an odd number of bit locations, parity testing

1st write	11010011	0	original data							
1st read	11010111	0	PE (parity error)							
D <del>&gt;</del> D̄	00101000	1	data are complemented							
2nd write	00101000	1	complemented data							
2nd read	00101100	1	PE (parity error)							
<del>D</del> →D	11010011	0	data are complemented							
	<b>A</b>									
hard error location										

Fig 2 Hard error correction with parity. Single parity bit can be used to correct single-bit hard error with double complement method. On each memory read, original parity bit is read and new parity check is done on bits in data word. New parity bit is then compared with that read for validity

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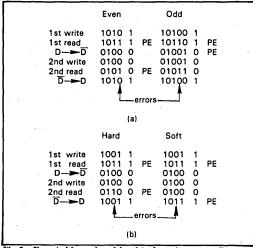


Fig 3 Even/odd word and hard/soft parity errors. Data words with even number of bits do not yield parity error on second read (a), nor soft error (b). Hard error, however, will be corrected

must be performed at different times during the correct cycle. In both cases, a double complement correct cycle can determine the type of error and, if it is hard, correct it (Fig 3).

If the bit in error is hard, the double complement correct can also be used to determine the bit's location in the data word. To do this, the data word and parity must be stored in a register when an error is detected. At the conclusion of the hard error correcting cycle, the location of the failing bit is determined by comparing the correct data with the contents of the register (Fig 4).

Thus, the use of a single parity bit not only makes it possible to deduce the error type, but also to locate and correct hard errors. This technique is useful for low cost terminal and word processing systems since, where retry is acceptable, the small amount of additional hardware

...the double complement method...also points the way to more sophisticated double-bit error correction and error management systems.

required can often eliminate the cost of an unscheduled service call. If a hard error can be detected, a double complement correct cycle will correct it, and the tech-

4 4 14	1010 1		
1st write	1010 1		
1st read	1011 1	PE, D <del>-≻R</del> EG	1011 1
D— <del>➤</del> D	0100 0		1
2nd write	0100 0		(÷)
2nd read	0101 0	PE	`j´
D	1010 1	compare with REG	1010 1
	A		
	L	error location =	0001 0

Fig 4 Locating hard errors with parity. Use of register for temporary storage enables double complement cycle to locate single hard error

nique combined with an error checking and correction (ECC) system can also provide extended error correction capability when hard errors are involved.

#### ECC and double complement

The double complement method in combination with an ECC system can correct additional errors, both hard and soft. The ECC system under discussion here uses the code implemented by National Semiconductor in the DP8400 ECC device (Fig 5) to perform 1-bit error correction and 2-bit error detection. In an ECC system for 16-bit data words, such as the one discussed here, six parity bits are generated. Each of the parity bits is assigned a value as a function of the sum of the 1s in a

0	1	2	3	4	5	6	7	8	9	0	1	1	3	4	1 5		
LSE															/ISB		
0	0	1	1	1	1	1	1	0	1	1	1		1	1	1	LSB	C
0	0	0	1	0	0	1	0	1	1	0	1	0	1	1	1	1	1
1	0	0	1	1	0	0	0	1	0	1	0	1	1	1	1	syndrome	2
^	1	1	0	0	0	0	1	1	1	1	0	1	0	1	1	words	3
. •		0	0	O	1	O	1	1	0	0	1	0	1	0	1	1 .	4
1	1																

Fig 5 Check bit generator for data words. Code used is that implemented in National Semiconductor's DP8400 ECC device

unique combination of selected bits in the data word. Partial word parity bits in an ECC system are referred to as check bits. For simplicity, odd parity will be used in the examples, although in most ECC systems, including those implemented with the DP8400, a combination of

Fig 6 Error check bits are generated by presenting the data word to ECC code matrix and noting corresponding 1s. In first row, bits 5 and 9 correspond with 1s in matrix. Thus, to maintain odd parity LSB of check bits is set to 1

odd and even parity is used to improve memory diagnostic capabilities.

An ECC code forms a matrix (Fig 6) to which a data word can be presented for the generation of check bits. Given a data word, such as 0000010001000000, and the uppermost horizontal row of the matrix in Fig 7, check bit 0 is to be assigned a value based on the sum of corresponding 1s in that row and the data word. Using odd parity, the corresponding 1s in locations 5 and 9 dictate

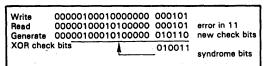


Fig 7 Generating syndromes for locating error. Syndrome word is result of exclusive OR (XOR) of error check bits.

No-error condition would result in syndrome word of all 0s

a value of 1 for the parity bit. For check bit 1, the selected location of correspondence is 9 only. Check bit 1 is assigned a value of 0 for odd parity. The complete set of check bits for this particular word is 000101 (05 HEX).

After check bit generation, the data and check bits go to the memory. During the read a new set of check bits are generated and compared against the check bits read from memory. The results of this check bit compare, an exclusive OR (XOR) function, are the syndromes (Fig 7). The single error indicating syndrome word is unique and is interpreted by the syndrome decoder to indicate the column in the matrix corresponding to the error location. The matrix or code is therefore a check bit generator for data, but a syndrome generator for error locations.

The...method in combination with an ECC system can correct additional errors, both hard and soft.

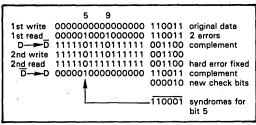


Fig 8 Correction of hard and soft errors. In the case of data word with one hard and one soft error, double complement method has corrected hard error and determined existence of soft error, which is then located by syndrome word and can be corrected

The check bits, or partial word parity bits, generated by modified Hamming codes and the code used in the DP8400, are also capable of providing complete error reporting. Since the single error reporting syndrome words contain an odd number of 1s and the total number of 1s is greater than one, 2-bit errors can easily be distinguished from a 1-bit or detectable triple-bit error. The DP8400 monolithic ECC device performs this error determination by counting the number of 1s in the error indicating syndrome words. When no error exists, the syndrome word contains no 1s, and when a single check is in error, a single 1 is present in the syndrome word. When an odd number of data bits are in error, the number of 1s in the syndrome word is odd and greater than 1 (3 or 5 in this example); if an even number of bits are in error, the syndrome word contains an even number of 1s greater than 0 (2, 4, or 6).

An ECC system implemented with the DP8400 can, at minimum, detect 100% of 2-bit errors; all of these errors are correctable if no more than one of them is soft. The device has complement write and read modes to allow the double complement correct technique to be used with no additional hardware, and other ECC devices can be used with additional components to implement the function.

In Fig 8, a soft error exists in location 5 and a hard error in location 9. During a memory read, the generated

The matrix or code is...a check bit generator for data, but a syndrome generator for error locations.

syndromes are the XOR of the single error that indicates syndrome words representing the error locations. 110001 (+) 001011 = 111010 [31 (+) 0B = 3A HEX]. Since a double error is indicated—an even number of 1s in the syndrome word—the data and check bits are complemented and placed in the output registers for presentation to the memory. After the memory write and subsequent read, the new data are complemented and stored in the data input latch. The error in location 5 remains in the data. A new set of check bits is generated from the data in the data input latch and compared with that in the check bit input latch, producing the syndrome word 110001 (31 HEX), which corrects the remaining error.

A detected double-bit error followed by a double complement correct cycle is properly reported as to initial error type. If the detected errors were both soft, for example, no change would occur in the data or check bit, and the ECC device error flags would again report a double-bit error. If, after the second read and complement, the error flags still report a single-bit error, the hard error (of a hard and soft combination) has been corrected and only the soft error remains. Of course, the single remaining error will be corrected in the normal manner by the ECC device. In the case of a double hard error, the error flags will report a no-error condition following the second read cycle, indicating that both errors were corrected and that the data are valid.

SPECIAL REPORT ON MEMORY SYSTEMS DESIGN

# SIMPLIFICATION OF 2-BIT ERROR CORRECTION

Bit by bit, errors can be detected and eliminated through the use of an error matrix

# by Bob Nelson

computer-generated code, which generally obeys the rules attributed to the Hamming code and many of its variations, can be used to extend error detection and error correcting efficiency in an error checking and correction system. Such a code has been implemented by National Semiconductor on the DP8400, an expandable error checking and correction device packaged in a 48-pin dual inline package. The DP8400 can be used in a minimum hardware implementation of a 2-bit error correction system which will serve as an introduction to the rotational syndrome word generator, and also lead the way to expanding the error correcting capabilities even further.

#### Syndrome words

The code used in an error checking and correction (ECC) system designed to correct 1-bit errors and detect 2-bit errors for 16-bit data words may be viewed as a 16 x 6 matrix (Fig 1). The matrix describes the error locations and the syndrome bit positions so that the upper left bit of the matrix defines the least significant bit (LSB) for both the error locations and the syndrome bit locations. Each vertical column of the matrix contains the syndrome word (syndrome bits) for that error location in

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the data word. For any number of errors, the syndrome word generated by presenting the data word to the matrix is the exclusive OR (XOR) of the syndrome words defined by the error positions. To correct an error, the location of the error must be uniquely identified, and thus the 16 vertical columns must each be unique. A modified Hamming code generates a unique syndrome word for every possible data bit error location and hence may be referred to as a syndrome word generator.

Using syndrome words containing an odd number of 1s is the most common "modification" to the Hamming code. By ensuring that the syndrome words (vertical columns in the matrix) contain either three or five 1s, all applicable error conditions may be defined by counting the syndromes. The absence of a syndrome (ie, a syndrome containing all 0s and no 1s) indicates no error; an odd number greater than one (3 or 5 in this case) defines the location of a single-bit error. Any simultaneous double error will provide a syndrome word containing an even number of 1s greater than zero, while a single 1 in the syndrome word is indicative of a failure in the check bit portion of memory.

The rotational syndrome word generator described here also contains an odd number of 1s in each syndrome word. One additional characteristic common to both the Hamming code and most of its modified versions is that byte parity is an integral part of the matrix itself. However, the code implemented in the DP8400 ECC device and discussed here does not consider byte parity, or word parity, as a part of the code itself.

A 2-bit error correction system may be implemented in either of two ways. A code designed to allow 2-bit error correction may be used, or an existing single-bit error correct code may be extended by adding a second, different code which will ensure that each syndrome

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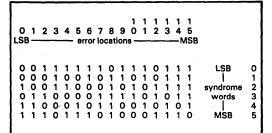


Fig 1 DP8400 generates unique syndrome word to indicate single-bit error position. Generated syndrome word containing all 0s means there is no error in data word.

word generated for any two error locations will be unique. Thus, a secondary, and different,  $16 \times 6$  matrix connected to the primary matrix to form a  $16 \times 12$  matrix will allow double-bit error correction if the XOR of the two 12-bit syndrome words produces a unique word for any two error locations.

#### Second matrix

The definition of an ECC matrix requires specifying a correspondence between error locations and syndrome words that defines the error location for each set of single-error syndromes. If a matrix is resequenced such that any error location corresponds to a syndrome word different from the original (primary) matrix, a second matrix has been created. For a 16-bit ECC matrix, 16!, or 2.092279 x 10^13, different codes exist. If a second code exists such that when it is combined with the first code (each containing the same syndrome words, but in a different sequence), a unique, larger syndrome word is generated for any two error locations, then an expandable code has been created (Fig 2).

The matrix, or code, used in the DP8400 device is defined such that if a second matrix, identical to the first but shifted by one bit position, is combined with the first, it would form just such a larger matrix. This matrix is fully rotational in that the secondary matrix need only be rotated, or shifted one error bit position to the left or right with respect to the primary matrix, to form larger, unique syndrome words regardless of the assigned correspondence of the primary matrix.

	0 LSI		2	3	4	5 — e			8 cat				1 2	3	1 4 —1	1 5 VIS	В	
l	0	0	1	1	1	1	1	1	o	1	1	1	0	1	1	1	LSB	0
1	0	0	0	1	0	0	1	0	1	1	0	1	0	1	1	1	1	1
1	1	0	0	1	1	0	0	0	1	0	1	0	1	1	1	1	1	2
ı	0	1	1	0	0	0	0	1	1	1	1	0	1	0	1	1		3
1	1	1	0	0	0	1	0	1	1	0	0	1	0	1	0	1	1	4
ı	1	1	1	0	1	1	1	0	1	0	0	0	1	1	1	0	syndrome	5
ı	0	1	1	1	1	1	1	0	1	1	1	0	1	1	1	0	words	6
1	0	0	1	0	0	1	0	1	1	0	1	0	1	1	1	0	1	7
١	0	0	1	1	0	0	0	1	0	1	0	1	1	1	1	1		8
ı	1	1	0	0	0	0	1	1	1	1	Ó	1	Ó	1	1	Ó		9
ı	1	0	0	0	1	0	1	1	0	0	1	Ó	1	Ó	1	1	ļ	10
١	1	1	0	1	1	1	0	1	Ó	Ó	0	1	1	1	Ó	1	MSB	11

Fig 2 Code in DP3400 can be expanded by adding second device with code shifted by one bit position. Note that bottom six bits of each column are identical to top six bits in column to immediate right.

Implementation of this code in the DP8400 allows the data word size to be extended beyond 80 bits, using one device for each additional 16-bit word or portion thereof. The code function as a rotational syndrome word generator exists for all these defined word widths (Fig. 3).

In addition to the rotational syndrome word generator, the DP8400 has two important features that permit an easy implementation of a 2-bit error correction system. During a memory read, the error indicating syndromes can be accessed directly by outputting them to the syndrome input/output (I/O) ports; syndrome can also be presented to the syndrome I/O ports to be XORed with the internally generated syndromes inside the DP8400. The internal syndrome decoder is provided with the result.

```
Error locations — O and 1
produce

HEX syndrome word — E34 (+) A78 = 44C
but

Error locations — 2 and 4
produce

HEX syndrome word — 1E9 (+) C65 = D8C
```

Fig 3 Unique syndrome is produced for each pair of error locations which is XOR of the locations. That syndrome can be decoded to identify pair in error.

If, for example, the internally generated 2-bit error syndromes are XORed with externally provided syndromes, representing one of the bits in error, the resulting syndromes representing the unknown error will be presented to the internal syndrome decoder. Once the unknown error is corrected, the data can be output to the data bus. The apparently correct data return zero syndromes (those containing all 0s) which, when XORed with the syndromes being injected, produce the syndromes representing the unknown error and present them to the syndrome decoder. This second error can then be corrected.

Using syndrome words containing an odd number of 1s is the most common 'modification' to the Hamming code.

As described, the DP8400 is implemented for a 16-bit system. This "primary" ECC device will provide at its syndrome I/O pins the primary, or least significant six, syndrome bits of an extended matrix ECC system. A "secondary" ECC device is interfaced to the memory system with the data pin-to-system data bit correspondence rotated by one bit position, thus producing the extended matrix just described. The second device requires a second set of check bits; these secondary, or most significant six, syndrome bits are provided by the second DP8400.

The resulting 12-bit syndrome word can be externally decoded to provide the syndromes to be injected to effect 2-bit error correction. In system use, the externally decoded syndromes will be stored in a register. After the syndrome 1/0 port of the primary ECC device has been "turned around," the register outputs are enabled to allow syndrome injection.

Each of the DP8400 devices provides a set of error flags. Since each device maintains an independent check bit field in memory, errors occurring within a given check bit field are easily and quickly determined. If the errors, regardless of number, are confined solely to the check bit field of one of the devices, a no-error condition will be indicated.

The syndrome word generated by this system is unique for any combination of 2-bit data errors; both devices see an even number, greater than zero, of 1s in the syndrome word (Fig 4). For 2-bit errors involving one data bit and one check bit in either the primary or secondary check bit fields, the DP8400s report an even, greater than zero, and odd number of 1s in the syndromes; again, the syndromes are unique. The remaining type of 2-bit error, that in which both errors occur in either the

Location/Error		Syndi	romes	Loca	tion/	Error	Syndromes		
Data	Sec	Prim	Sec	Prim	Data	Sec	Prim	Sec	Prim
2	0	0	even	even	1	0	1	odd	even
1	1	1	even	even	2	1	0	odd	ever
1	0	0	odd	odd	0	1	2	odd	ever
0	1	1	odd	odd	1	1	0	even	odd
3	0	0	odd	odd	2	0	1	even	odd
1	0	2	odd	odd	Ò	2	1 .	even	odd
1	2	0	odd	odd					

Fig 4 Number and type of errors can be determined by looking at combination of even or odd numbers of 1s in the primary and secondary check bit fields.

primary or secondary check bit fields, produces its own unique syndrome word. However, since one DP8400 reports an even number of 1s in its syndrome word and the other reports all 0s, the data are known to be valid. In addition, in this particular 2-bit error correct system, nearly half of the 3-bit errors result in unique syndrome words and are therefore correctable as well.

#### Decoding the syndromes

A programmable read only memory (PROM) or electrically programmable read only memory (EPROM) is required as an external syndrome decoder for this 2-bit error correction system. The PROM address inputs are provided by the 12 syndrome bits generated by the two ECC devices. The least significant six bits of the PROM output byte provide, when required, the syndrome bits for subsequent injection into the primary DP8400. The remaining two bits of the PROM output byte provide flags defining the type of error and the contents of the six LSBs of the PROM output byte [Fig 5(a)].

The DP8400's error flags provide initial error determination; if an error that is not a single-bit error occurs, the external syndrome decoder will provide further error determination. Some types of error do not require syndrome injection and are referred to as "zero-pass" correctable errors. An example of such an error is one with a data bit and a secondary check bit in error. This type of error is corrected by the primary ECC device. An error type that requires "one-pass" correction is one with two data bits in error. In this case, syndromes representing a known error are injected into the DP8400,

allowing correction of the unknown error. The remaining single error is then corrected.

The remaining error type, the "two-pass" error, can sometimes be a correctable 3-bit error. The syndromes representing a 2-bit error condition are injected, allowing correction of one error. The remaining 2-bit error produces a new set of syndromes which requires external (second-pass) decoding to produce a set of

```
MSB
                     LSB
 7 6 5 4 3 2 1 0
   1 pass correctable
                            2 pass correctable
 ō
                            bits 0 to 5 = syndromes
                            not correctable
 O pass correctable
                            bits 0 to 5 <> syndromes
                          (a)
                     LSB
MSB
             3 2 1 0
   X X X X X X 1
X X X X X 1 X
X X X X 1 X X
X X 0 0 1 X X
X X 0 1 X X X
X X 1 1 X X X
X X 1 1 X X X
                           primary check bit(s) in error
 1
                           secondary check bit(s) in error
 1
                           data bit(s) in error
                            1 bit in error
                           2 bits in error
 1
                           3 bits in error
                           4 or more bits in error
    1 0 X X X X X
 1
                           output data from secondary ECC
 1 1 1 X X X X X
                           output data from primary ECC
```

Fig 5 When a PROM is used as external syndrome decoder, its output byte can supply additional data about the error and how it is to be most efficiently corrected.

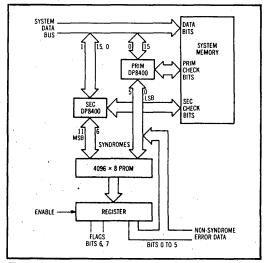


Fig 6 A 2-bit ECC system can be implemented with two DP\$400s, a 4k-byte PROM for external syndrome decoding, and a register for temporary storage of syndromes error data. Note that the altered sequence of the lines from the secondary DP\$400 reflects the bit rotation needed to expand the unique matrix.

```
3000 ******
 3010 '***
                   'DC16AROM.BAS' Bob Nelson - Sunnyvale CA - 9/15/81
                   This program generates the syndrome decoder ROM code for use in implementing a primary syndrome injection two bit correction code generated by a single bit left rotation of the secondary matrix. The primary is a Rotational Syndrome Generator as defined by National Semiconductor in the DP8400. The LPRINT routine may be replaced with a
 3020 ****
 3030 ****
                                                                                                                ***
 3040 ****
 3050 ****
 3060 '***
                                                                                                                ***
 3070 '***
                                                                                                                ***
 3080 ****
                    FILE generator or OUTP routine to facilitate the use of a
 3090 ****
                3100
 3110 '
3120 DEFINT A-Z:DIM SYND(16), PRI(16), ROM(4096,1)
3130 READ A:B=A:FOR C=0 TO 14:READ D:SYND(C)=D*64+A:PRI(C)=A:A=D
 3140 NEXT:SYND(15)=B*64+A:PRI(15)=D
3150 DATA 52,56,41,7,37,49,33,25,62,11,13,19,44,55,47,31: 'NSC 80F/2 MATRIX 3160 ROM(0,1)=224:FOR A=1 TO 4095:ROM(A,1)=184:NEXT 3170 FOR A=0 TO 13:FOR B=A+1 TO 14:FOR C=B+1 TO 15 3180 AD=SYND(A) XOR SYND(B) XOR SYND(C):AE=PRI(A) XOR PRI(B)
                                                                                                 300 - 560
 3190 IF ROM(AD,1)=184 THEN ROM(AD,1)=AE+64 ELSE ROM(AD,1)=183
3200 NEXT:NEXT:NEXT
3210 FOR A=0 TO 14:FOR B=A+1 TO 15
3220 AD=SYND(A) XOR SYND(B):ROM(AD,1)=PRI(A)
3230 FOR C=0 TO 5:P=2^C
                                                                                                   1200 - 120
3240 IF (AD AND P)=0 THEN AE=AD+P ELSE AE=AD-P 3250 IF (PRI(A) AND P)=0 THEN AF=PRI(A)+P+64 ELSE AF=PRI(A)-P+64
3260 IF ROM(AE,1)=184 THEN ROM(AE,1)=AF ELSE ROM(AE,1)=183
3270 NEXT
3280 FOR C=0 TO 5:S=64*2^C
                                                                                                   '210 - 720
3290 IF (AD AND S)=0 THEN AE=AD+S ELSE AE=AD-S
3300 IF ROM(AE,1)=184 THEN ROM(AE,1)=PRI(A) ELSE ROM(AE,1)=183
3310 NEXT: NEXT: NEXT
3320 FOR A=0 TO 15:AD=SYND(A):ROM(AD,1)=228
3330 FOR B=0 TO 5:P=2^B
                                                                                                   '100 - 16
'101 - 96
3340 IF (AD AND P)=0 THEN AE=AD+P ELSE AE=AD-P
3350 ROM(AE,1)=205
3360 FOR C=B+1 TO 5:P=2^C
                                                                                                   102 - 240
3370 IF (AE AND P)=0 THEN AF=AE+P ELSE AF=AE-P
3380 IF ROM(AF,1)=184 THEN ROM(AF,1)=213 ELSE ROM(AF,1)=183
3390 NEXT: NEXT
3400 FOR B=0 TO 5:S=64*2^B
3410 IF (AD AND S)=0 THEN AE=AD+S ELSE AE=AD-S
                                                                                                   1110 - 96
3420 ROM(AE,1)=238
3430 FOR C=B+1 TO 5:S=64*2^C
                                                                                                   120 - 240
3340 IF (AE AND S)=0 THEN AF=AE+S ELSE AF=AE-S 3450 IF ROM(AF,1)=184 THEN ROM(AF,1)=245 ELSE ROM(AF,1)=183
3460 NEXT: NEXT
3470 FOR B=0 TO 5:P=2^B:FOR C=0 TO 5:S=64*2^C
                                                                                                   '111 - 596
3480 IF (AD AND P)=0 THEN AE=AD+P ELSE AE=AD-P
3490 IF (AD AND S)=0 THEN AE=AE+S ELSE AE=AE-S
3500 FOR D=0 TO 5:E=2^D

3510 IF ROM(AE,1)=D THEN ROM(AE,1)=183:GOTO 3540

3520 IF ROM(AE,1)=184 THEN ROM(AE,1)=P
3530 NEXT D
3540 NEXT C:NEXT B:NEXT A
3550 FOR A=0 TO 5:FOR B=0 TO 5
                                                                                                              36
3560 AD=2^A+64*2^B:ROM(AD,1)=235
3570 FOR C=A+1 TO 5:AE=AD+2^C
3580 IF ROM(AE,1)=184 THEN ROM(AE,1)=243 ELSE ROM(AE,1)=183
                                                                                                   1012 -
3590 NEXT
3600 FOR C=B+1 TO 5:AE=AD+64*2^C
3610 IF ROM(AE,1)=184 THEN ROM(AE,1)=243 ELSE ROM(AE,1)=183
3620 NEXT: NEXT: NEXT
3630 FOR A=0 TO 5:AD=2^A:ROM(AD,1)=225
                                                                                                   '001 -
                                                                                                                6
3640 FOR B=A+1 TO 5:AE=AD+2/B:ROM(AE,1)=233
3650 FOR C=B+1 TO 5:AE=AD+2/B:ROM(AE,1)=233
3660 IF ROM(AF,1)=184 THEN ROM(AF,1)=241
                                                                                                   1002 -
                                                                                                              1.5
                                                                                                   1003 -
3670 NEXT: NEXT: NEXT
3680 FOR A=0 TO 5:AD=64*2^A:ROM(AD,1)=226
                                                                                                   '010 ~
3690 FOR B=A+1 TO 5:AE=AD+64*2^B:ROM(AE,1)=234
3700 FOR C=B+1 TO 5:AF=AD+64*2^C
                                                                                                   1020 -
                                                                                                              15
                                                                                                   1030 -
                                                                                                               20
3710 IF ROM(AF,1)=184 THEN ROM(AF,1)=242
3720 NEXT: NEXT: NEXT
3730 B=0:C=0:FOR A=0 TO 4095:H$=HEX$(ROM(A,1)):
3740 B=B+1:C=C+1:IF LEN(H$)=1 THEN H$="0"+H$
3750 LENINT USING "\ ";H$;:IF C<>16' THEN 3770
3760 C=0:LPRINT" ";HEX$(A)
                                                                                 'LPRINT ARRAY
3770 IF B< >256 THEN 3790
3780 B=0:LPRINT:LPRINT
3790 NEXT
```

```
'DC16AMAP.BAS' Bob Nelson - Sunnyvale CA - 9/15/81
This program generates the syndrome maps for a primary
syndrome injection implementation of a 16 bit word two
1010 ****
                                                                                                                 ***
1020 ****
                                                                                                                  ***
1030 '***
                                                                                                                  ***
                   bit error correct system utilizing a Rotational Syndrome
Word Generator as implemented in the DP8400 by National
1040 '***
                                                                                                                  ***
1050 '***
                                                                                                                  ***
                    semiconductor. These maps are based on single bit left rotation of the secondary matrix. The 'c' and 'd' notes in the maps denote non-correctable and non-detectable
1060 '***
                                                                                                                  ***
1070 '***
                                                                                                                  ***
1080 '***
                                                                                                                  ...
1090 '***
                                                                                                                  ***
                   three bit error conditions......
1100 ****
1110
1120 DEFINT A-Z:DIM SYND(16), PRI(16), ROM(1132,1):P$="PRIMARY":S$="SECONDARY"
1130 READ A:B=A:FOR C=0 TO 14:READ D:SYND(C)=D*64+A:PRI(C)=A:A=D
1140 NEXT:SYND(15)=B*64+A:PRI(15)=D
1150 DATA 52,56,41,7,37,49,35,25,62,11,13,19,44,55,47,31: 'NSC 80F/2 MATRIX 1160 LPRINT "ONE DATA ERROR SYNDROME MAP":LPRINT 1170 FOR A=0 TO 15:LPRINT USING"##";A;:LPRINT" ";:NEXT:LPRINT:LPRINT
1180 FOR A=0 TO 15:LPRINT HEX$(SYND(A));" ";:NEXT:LPRINT
1190 FOR A=1 TO 4:LPRINT:NEXT
1200 LPRINT TWO DATA ERROR CORRECT SYNDROME MAP":LPRINT
1210 FOR A=1 TO 15:LPRINT USING ##";A;:LPRINT" ";:NEXT:LPRINT:LPRINT
1220 FOR A=0 TO 14:FOR B=A+1 TO 15:AD=SYND(A) XOR SYND(B) '200
                                                                                                        200 - 120
1230 ROM(X,1)=AD:H$=HEX$(AD):IF LEN(H$)=2 THEN H$="0"+H$
1240 LPRINT H$;" ";:X=X+1:NEXT B:LPRINT USING"###";A
1250 LPRINT TAB((A+1)*5+1);:NEXT A:FOR A=1 TO 4:LPRINT:NEXT
                                                                                                      '111 - 576
1260 FOR A=0 TO 5:S=64*2^A:FOR B=0 TO 5:P=2^B:FOR C=0 TO 15
1270 AD=SYND(C):IF (AD AND P)=0 THEN AD=AD+P ELSE AD=AD-P
1280 IF (AD AND S)=0 THEN AD=AD+S ELSE AD=AD-S
1290 ROM(X,1)=AD:X=X+1:NEXT:NEXT:NEXT:A$=" "
1300 LPRINT"ONE DATA, ONE PRI, ONE SEC CHECK ERROR SYNDROME MAPS":LPRINT
1310 LPRINT:X=120:FOR A=0 TO 5:LPRINT"SECONDARY CHECK BIT";A:LPRINT
1320 FOR F=0 TO 15:LPRINT USING"##";F;:LPRINT"
1330 FOR B=0 TO 5:FOR C=0 TO 15:FOR E=0 TO 119
                                                                           ";:NEXT F:LPRINT:LPRINT
1340 IF ROM(E.1)=ROM(X.1) THEN A$="d":E0=E0+1:GOTO 1370 ELSE NEXT E
1350 FOR D=120 TO 695: IF D=X THEN D=D+1
1360 IF ROM(D,1)=ROM(X,1) THEN A$="c":E2=E2+1 ELSE NEXT D
1370 H$=HEX$ (ROM(X,1)):IF LEN(H$)=2 THEN H$="0"+H$
1380 LPRINT H$;A$;:X=X+1:A$=" ":NEXT C:LPRINT USING"####";B
1390 NEXT B: LPRINT: LPRINT: NEXT A
1400 LPRINT"576 ONE DATA, ONE PRI, ONE SEC CHECK errors are possible."
1410 LPRINT E0; "TWO DATA errors are not detectable.":LPRINT E2;
1420 LPRINT "ONE DATA, ONE PRI, ONE SEC CHECK errors are not correctable."
1430 LPRINT 100*(1576-E0)/576):"PERCENT DETECT - ";
1440 LPRINT 100*((576-E0-E2)/576; "PERCENT CORRECT"
1450 FOR A=1 TO 4:LPRINT:NEXT:EA=E0:E0=0:EC=E2:E2=0
1460 X=0:FOR A=0 TO 15:AD=SYND(A):ROM(X,1)=AD:X=X+1:NEXT
                                                                                                        100 - 16
                                                                                                       '011 - 36
1470 FOR A=0 TO 5:P=2^A:FOR B=0 TO 5:S=64*2^B
1480 AD=P+S:ROM(X,1)=AD:X=X+1:NEXT:NEXT
1490 FOR A=0 TO 15:FOR B=A+1 TO 15:FOR C=B+1 TO 15
                                                                                                       '300 - 560
1500 AD=SYND(A) XOR SYND(B) XOR SYND(C)
1510 ROM(X,1)=AD:X=X+1:NEXT:NEXT:NEXT
1520 FOR A=0 TO 5:P0=2^A:FOR B=A+1 TO 5:P1=2^B
                                                                                                        102 - 240
1530 FOR C=0 TO 15:AD=SYND(C):IF (AD AND PO)=0 THEN AD=AD+PO ELSE AD=AD-PO
1540 IF (AD AND Pl)=0 THEN AD=AD+Pl ELSE AD=AD-Pl
1550 ROM(X,1)=AD:X=X+1:NEXT:NEXT:NEXT
1560 FOR A=0 TO 5:S0=64*2^A:FOR B=A+1 TO 5:S1=64*2^B
                                                                                                       120 - 240
1570 FOR C=0 TO 15:AD=SYND(C):IF (AD AND SO)\(^1\)0 THEN AD=AD+SO ELSE AD=AD-SO 1580 IF (AD AND S1)=0 THEN AD=AD+S1 ELSE AD=AD-S1
1590 ROM(X,1)=AD:X=X+1:NEXT:NEXT:NEXT
1600 LPRINT"THERE DATA BIT ERROR SYNDROME MAPS": LPRINT: LPRINT
1610 X=52:AS=" ":FOR A=0 TO 13:LPRINT"DATA bit";A:LPRINT 1620 FOR D=A+2 TO 15:LPRINT USING"##";D;:LPRINT" ";:NEX
                                                                                ";:NEXT:LPRINT:LPRINT
1630 FOR B=A+1 TO 14:FOR C=B+1 TO 15:FOR E=16 TO 51
1640 IF ROM(E,1)=ROM(X,1) THEN A$="d ":E0=E0+1:GOTO 1690 ELSE NEXT E
1650 FOR F=612 TO 1091
1660 IF ROM(F,1)=ROM(X,1) THEN A$="c ":E1=E1+1:GOTO 1690 ELSE NEXT F
1660 IF ROM(F,1)=ROM(X,1) THEN A$="C ":E!=E!+1:GOTO 1690 ELSE NI
1670 FOR G=52 TO 611:IF G=X THEN G=G+1
1680 IF ROM(G,1)=ROM(X,1) THEN A$="C ":E2=E2+1 ELSE NEXT G
1690 H$=HEX$(ROM(X,1)):IF LEN(H$)=2 THEN H$="O"+H$
1700 LPRINT H$;A$;:X=X+!A$=" ":NEXT C:LPRINT USING "###";B
1710 LPRINT TAB((B-A)*5+1);:NEXT B:LPRINT:LPRINT:NEXT A
1720 LPRINT"560 THREE DATA BIT errors are possible. ":LPRINT E0;
1720 LPRINT"560 THREE DATA BIT errors are possible. "LIPRINT E0;
1730 LPRINT"ONE PRI, ONE SEC CHECK errors are not detectable.":LPRINT El;
1740 LPRINT"ONE DATA, TWO PRI or TWO SEC CHECK errors are not correctable."
1750 LPRINT E2; "TRREE DATA BIT errors are not correctable."
1760 LPRINT 100*((560-E0)/560); "PERCENT DETECT - ";
1770 LPRINT 100*((560-E0-E1-E2)/560); "PERCENT CORRECT"
1780 FOR A=1 TO 4:LPRINT:NEXT A:EA=EA+E0:EB=EB+E1:EC+EC+E2
1790 LPRINT"ONE DATA, TWO PRIMARY CHECK ERROR SYNDROME MAPS":LPRINT:LPRINT 1800 A$=" ":E0=0:E1=0:E2=0:FOR A=0 TO 4:LPRINT"PRIMARY check bit";A:LPRINT 1810 FOR F=0 TO 15:LPRINT USING "##";F;:LPRINT" ";:NEXT F:LPRINT:LPRINT
1820 FOR B=A+1 TO 5:FOR C=0 TO 15:FOR E=852 TO 1091
```

```
1830 FOR F=52 TO 611
1840 IF ROM(F,1)=ROM(X,1) THEN A$="c":E2=E2+1:GOTO 1860 ELSE NEXT F
1850 IF ROM(E,1)=ROM(X,1) THEN A$="c":E1-E1+1 ELSE NEXT E
1860 H$=HEX$(ROM(X,1)):IF LEN(H$)=2 THEN H$="0"+H$
 1870 LPRINT H$; A$; : X = X + 1: A$ = " ": NEXT C: LPRINT USING "####"; B
 1880 NEXT B:LPRINT:LPRINT:NEXT A
1890 LPRINT"240 ONE DATA, TWO PRIMARY CHECK errors are possible."
1900 LPRINT E1; "ONE DATA, TWO SECONDARY CHECK errors are not correctable."
1910 LPRINT E2; "THREE DATA BIT errors are not correctable."
1920 LPRINT"100 PERCENT DETECT - ";100*((240-E1-E2)/240); "PERCENT CORRECT"
 1930 FOR A=1 TO 4:LPRINT:NEXT A:EB=EB+E1+E2:E1=0:E2=0
 1940 LPRINT"ONE DATA, TWO SECONDARY CHECK ERROR SYNDROME MAPS": LPRINT
1950 LPRINT:FOR A=0 TO 4:LPRINT"SECONDARY check bit";A:LPRINT
1960 FOR F=0 TO 15:LPRINT USING "##";F;:LPRINT" ";:NEXT F:LPRINT:LPRINT
 1970 FOR B=A+1 TO 5:FOR C=6 TO 15:FOR E=612 TO 851
 1980 FOR F=52 TO 611
1990 IF ROM(F,1)=ROM(X,1) THEN A$="c":E2=E2+1:GOTO 2010 ELSE NEXT F
2000 IF ROM(E,1)=ROM(X,1) THEN A$="c":E1=E1+1 ELSE NEXT E
2010 H$=HEX$(ROM(X,1)):IF LEN(H$)=2 THEN H$="0"+H$
 2020 LPRINT H$; A$; :X = X + 1: A$ = " ": NEXT C: LPRINT USING "####"; B
2030 NEXT B: LPRINT: LPRINT: NEXT A
2030 NEXT BI-PRINT::DRINT::NEXT A
2040 LPRINT"240 ONE DATA, TWO SECONDARY CHECK errors are possible."
2050 LPRINT E1; "ONE DATA, TWO PRIMARY CHECK errors are not correctable."
2060 LPRINT E2; "THREE DATA BIT errors are not correctable."
2070 LPRINT"100 PERCENT DETECT - ";100*((240-E1-E2)/240); "PERCENT CORRECT"
2080 FOR A=1 TO 4:LPRINT:NEXT A:EB=EB+E1+E2:A$=" ":CO=1:C1=64
2090 IF W=1 THEN P$="SECONDARY":S$="PRIMARY":CO=64:C1=1
2100 X=0:FOR A=0 TO 15:AD=SYND(A):FOR B=0 TO 5:P=C0*2^B
                                                                                                            '101/110 - 96
2105 IF (AD AND P)=0 THEN AE=AD+P ELSE AE=AD-P
2110 ROM(X,1) = AE: X = X + 1: NEXT B: NEXT A
2120 FOR A=0 TO 5:S=C1*2^A:FOR B=0 TO 15:FOR C=B+1 TO 15
                                                                                                            1210/201 - 720
2130 AD=SYND(B) XOR SYND(C):IF (AD AND S)=0 THEN AE=AD+S ELSE AE=AD-S
2140 ROM(X,1)=AE:X=X+1:NEXT C:NEXT B:NEXT A
2150 FOR A=0 TO 5:AD=C1*2^A:FOR B=0 TO 4:AE=AD+C0*2^B
                                                                                                            '012/021 - 90
2160 FOR C=B+1 TO 5:ROM(X,1)=AE+CO*2^C:X=X+1:NEXT:NEXT:NEXT
2170 A$=" ":LPRINT"TWO DATA, ONE ";:LPRINT S$;
2180 LPRINT" CHECK ERROR SYNDROME MAPS": LPRINT: LPRINT
2190 X=96:E0=0:E1=0:E2=0:FOR A=0 TO 5:LPRINT S$;
2200 LPRINT" check bit";A:LPRINT
2210 FOR F=1 TO 15:LPRINT USING"##";F;:LPRINT"
                                                                                     ";:NEXT F:LPRINT:LPRINT
2220 FOR B=0 TO 14:FOR C=B+1 TO 15;FOR D=0 TO 95
 2230 IF ROM(D,1)=ROM(X,1) THEN A$="d ":E0=E0+1:GOTO 2280 ELSE NEXT D
2240 FOR G=96 TO 815: IF G=X THEN G=G+1
2250 IF ROM(G,1)=ROM(X,1) THEN A$="c ":E2=E2+1:GOTO 2280 ELSE NEXT G
2260 FOR E=816 TO 905
2270 IF ROM(E,1)=ROM(X,1) THEN A$="c ":E1+E1+1 ELSE NEXT E
2280 H$=HEX$(ROM(X,1)):IF LEN(H$)=2 THEN H$="0"+H$
2290 LPRINT H$;A$;:X=X+1:A$=" ":NEXT C:LPRINT USING"####";B
 2300 LPRINT TAB((B+1)*5+1);:NEXT B:LPRINT:LPRINT:NEXT A
2310 LPRINT"720 TWO DATA, ONE ";:LPRINT MID$(S$,1,3);
2320 LPRINT" CHECK errors are possible."
2330 LPRINT E0; "ONE DATA, ONE ";:LPRINT MID$(P$,1,3);
2340 LPRINT CHECK errors are not detectable.":LPRINT E1; "TWO ";
2350 LPRINT MID$(P$,1,3);:LPRINT", ONE ";:LPRINT MID$(S$,1,3);
2360 LPRINT" CHECK errors are not correctable."
2370 LPRINT E2;"TWO DATA, ONE ";:LPRINT MID$(S$,1,3);
2380 LPRINT" CHECK errors are not correctable."
2390 LPRINT 100*((720-E0)/720); "PERCENT DETECT - ";
2400 LPRINT 100*((720-E0-E1-E2)/720); "PERCENT CORRECT"
2410 FOR A=1 TO 4:LPRINT:NEXT:EA=EA+E0:EB=EB+E1:EC=EC+E2
2420 LPRINT"TWO ";:LPRINT MID$(P$,1,3);:LPRINT", ONE ";:LPRINT MID$($$,1,3);
2430 LPRINT" CHECK ERROR SYNDROME MAPS": LPRINT: LPRINT
2440 X=816:E0=0:E1=0:E2=0:FOR A=0 TO 5:LPRINT S$;
2450 LPRINT" check bit";A:LPRINT
24460 FOR F=1 TO 5:LPRINT USING "##";F;:LPRINT"
2470 FOR B=0 TO 4:FOR C=B+1 TO 5
                                                                                     "::NEXT F:LPRINT:LPRINT
2440 FOR B=0 TO 4:FOR C=B+1 TO 5
2480 FOR D=96 TO 815:IF ROM(D,1)=ROM(X,1) THEN A$="c ":El=El+1 ELSE NEXT D
2490 H$5-HEX$(ROM(X,1)):IF LEN(H$)=2 THEN H$5="0"+H$
2500 LPRINT H$7,A$7:X=X+1:A$=" ":NEXT C:LPRINT USING"##";B
2510 LPRINT TAB(|B+1)*5+1);:NEXT B:LPRINT:LPRINT:NEXT A:LPRINT"90 TWO ";
2520 LPRINT MID$(P$,1,3);:LPRINT", ONE ";:LPRINT MID$(S$,1,3);
2530 LPRINT" CHECK errors are possible. ":LPRINT El;"TWO DATA, ONE ";
2540 LPRINT MID$($$,1,3);:LPRINT" CHECK errors are not correctable."
2550 LPRINT"100 PERCENT DETECT - ";100*((90-El)/90);"PERCENT CORRECT"
2560 FOR A=1 TO 4:LPRINT.NEXT A.FARPATEDETED.TENTEDETET.
2560 FOR A=1 TO 4:LPRINT:NEXT A:EA=EA+E0:EB=EB+E1:EC=EC+E2
2570 IF W=0 THEN W=1:GOTO 2090
2580 FOR A=1 TO 4:LPRINT:NEXT
2590 LPRINT"3290 THREE BIT ERRORS (all types) are possible."
2600 LPRINT EA; "of these errors cannot be detected."
2610 LPRINT EB+EC; "of these errors cannot be located."
2620 LPRINT 100*((3290-EA)/3290); "PERCENT DETECT - ";
2630 LPRINT 100*((3290-EA-EB-EC)/3290); "PERCENT CORRECT"
```

single-bit error syndromes. The error status at this point is that of a "one pass" error, and correction proceeds accordingly.

When a zero-pass error or a noncorrectable error occurs, the six LSBs from the PROM provide additional information. For example, a hexadecimal coded output from the PROM [Fig 5(b)] defines a 2-bit error in which one bit in error is a data bit and the other a primary check bit. The primary ECC device detects a 2-bit error while the secondary device detects only the data bit in

Some types of error do not require syndrome injection and are referred to as "zero-pass" correctable errors.

error. Bit 5 of the PROM output directs the secondary device to output corrected data to the system. In most cases, bit 5 is a 1, and corrected data are output from the primary ECC device. Bits 0 through 4 of the PROM output define the error type and the number of bits in error (Fig 6) when the MSB (bit 7) is a 1. When the MSB is a 0, syndromes are required for correction, and bits 0 through 5 represent those syndromes.

The first of the two programs provided here is called "DC16AROM.BAS," and is a listing in hexadecimal representing the contents of the syndrome decoding PROM. The file may be presented to an output port for loading a PROM programmer if minor program changes are made. The second program, called "DC16AMAP.BAS," generates all the required syndrome maps, which include flags for all correctable 3-bit errors. These programs were written in Microsoft Basic and are compilable.

SYSTEM DESIGN/MEMORY SYSTEMS

# EFFORTLESS ERROR MANAGEMENT

Basic application of error management techniques is based on error history, including the double complement error correction cycle

# by Bob Nelson

hen implemented only in hardware, error management is generally limited to simple error logging. In most systems, error logging hardware is designed to capture the location of one error and use this information for maintenance purposes. In more sophisticated systems, however, software extends the error management function: after hardware obtains. error information, data are accumulated on disk to expand storage capacity for information relating to error locations. Beyond the error information storage function of error management, which is useful for maintenance, some systems implement a correction procedure based on error history. If two errors occur in a memory word where an error has previously occurred, it is likely that both errors can be corrected. The basic error management system described in this article will provide a high correction rate for all 2-bit errors, except when two soft errors simultaneously occur in a memory word with no error history.

## Error management system

The error management system comprises the central processing unit (CPU), the system memory, an error checking and correction (ECC) device, and an error management unit (EMU). The CPU is a 16-bit machine

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and requires commensurate memory. Actual memory, including the six check bits that the ECC device requires, is 22 bits wide. The ECC device is based on the DP8400 monolithic ECC unit manufactured by National Semiconductor. The EMU is a hypothetical device that can be implemented in hardware, partially or entirely, depending on system requirements.

The DP8400 provides several functions and features that allow easy implementation of a minimum hardware error management system. Error indicating syndrome words must be available to the EMU directly and syndrome injection capability must exist. (See "Simplification of 2-Bit Error Correction," Jan 1982, pp 127-136, for a discussion of the DP8400's syndrome input/output ports.) The DP8400 also provides the hardware required to perform a double complement correct cycle. Error flags must be provided to discriminate between 2-bit and detectable 3-bit errors; the DP8400 provides three such flags to include this function.

Vertical columns in the matrix shown in Fig 1 represent the single data bit error indicating syndrome words. A double data bit error syndrome word results from exclusive ORing (XOR) the two single-bit error indicating syndrome words that correspond to the bit locations in error. A detectable triple data bit syndrome word is any one of the ten syndrome words, not included as part of the matrix, which contains either three or five 1s. Syndrome words that represent check bit errors contain 1s in the syndrome word bit positions corresponding to the check bits in error, and 0s in the remaining bit positions. An error condition involving the data and check bit fields provides a syndrome word that represents the data bit(s) in error, XORed with a syndrome word representing the check bit(s) in error.

#### Error management unit

The EMU is memory intensive and uses memory in the form of an associative stack. Three fields constitute each of the 16 words in the stack: the 8-bit address field, which is the associative portion of the word; the 2-bit

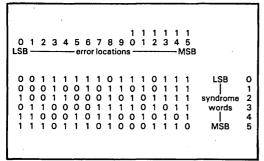


Fig 1 DP8400 syndrome word generator. Presenting errors to unique matrix produces syndrome words.

tag field; and the 6-bit syndrome field (Fig 2). The pointer addresses the stack. The EMU also contains a syndrome comparator, a temporary syndrome register, and a tag bit attribute register and comparator. The EMU monitors most ECC flags and provides flags of its own both to the ECC device and to the CPU; monitoring the memory address and comparing that address to the

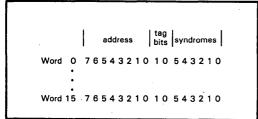


Fig 2 Associative stack organization. Of 16-bit address, eight address bits are most significant bits. Tag bits indicate type of error, and syndrome bits contain syndrome word.

stack's address field is a major function of the EMU. When the "stack full" flag is off, however, the number of words in the match area is limited by the location of the stack pointer. If a match occurs, ie, if the current memory address is an address at which an error occurred previously, the information obtained from the previous error can be used to correct more than one error bit. Each EMU function will be defined in a subsequent section of this article.

## Single-bit error: first occurrence

Absence of a match, accompanied by single-bit error indicating flags, defines the first occurrence of such an

Tag Bits	Information Status
00 01 10 11	soft single-bit error firm single-bit error hard single-bit error hard double-bit error
11	

Fig 3 Tag bit field of stack indicates error type for more efficient processing by error management system. Tag bit field could be extended in other systems to provide more error information.

and the current address. The error may be in the data bit or check bit field of memory. Error address, tag bits (Fig 3), and single-bit error indicating syndrome word are stored in the EMU stack. Tag bits are assigned a value of 00, indicating a soft single-bit error. The stack pointer is then incremented and the ECC device corrects

the single-bit error in the usual way. Stored syndromes contain an odd number of 1s. In Fig 4, data bit 5 fails at memory address 52 HEX, check bit 3 fails at address 45 HEX, and data bit 9 fails at address C7 HEX. Since the errors have not occurred previously at these addresses, they are given a tag bit value of 00. Logging errors should not impact the speed or function of the ECC system in performing single-bit error correction.

#### Double-bit error: first occurrence

When a double-bit error occurs at an address with no error history, the EMU exercises the only available option, a double complement correct cycle. As the ECC device enters the complement write mode, the syndrome word that represents the double-bit error condition is stored in the temporary syndrome register. Then the ECC system performs a double complement correct cycle to generate a second set of error flags. If two soft errors caused the initial indication of a 2-bit error, the second set of error flags will also indicate two errors and represent a noncorrectable condition. Any double-bit error situation other than that of two soft errors will produce error flags that indicate a correctable condition at the conclusion of the double complement correct cycle.

# One hard and one soft

Error flags produced after the second complement of the double complement correct cycle indicate a single error if the initial error condition was one hard and one soft. At that point, the hard error will have been "corrected" and the remaining soft error indicated. The ECC device will generate a new single-bit error indicating syndrome word, which the EMU will XOR with the previously stored double-bit error indicating syndrome word. The result, which is the single-bit hard error indicating syndrome word, is stored in the stack.

To identify the bit as a single hard error, the tag bit field is set to a value of 10. After the error information is stored, the stack pointer is incremented. The ECC device corrects the single error in the usual manner. The remaining soft error may be either a check bit error or a data bit error. Fig 5 illustrates a soft error in data bit location 2 and a hard error in data bit location 11. A double complement cycle corrects the error in location 11. Representing the soft error, a new syndrome word is then XORed with the original syndrome word to produce

		error address tag bits syndromes	
Word	0	1010001000110001	data bit 5
Word	1	0100010100001000	check bit 3
		1100011100001011	data bit 9
Word	3	XXXXXXXXXXXXXXX	
	•		4.0
	•	•	*.
ł	•		
Word 1	15	xxxxxxxxxxxxxxx	•

Fig 4 Logging errors on EMU stack. Single-bit errors occurring at addresses with no previous error history receive tag bit value of 00.

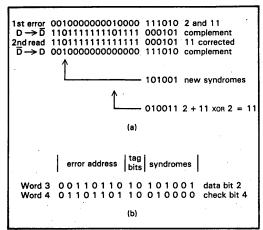


Fig 5 After correcting hard error in bit position 11 (a), system stores hard error syndrome on associative stack (b) and sets tag bit field to indicate single-bit hard error.

Word Word Word Word Word Word	0 1 2 3 4 5 6	error address   tag   bits   syndromes   data bit 5   1 0 1 0 0 0 1 0 1 0 0 0 1 1 0 0 0 1   data bit 5   1 0 0 0 1 1 0 1 0 1 0 1   data bit 9   0 0 1 1 0 1 1 0 1 0 1 0 1 0 1   data bit 2 0 1 1 0 1 1 0 1 1 0 1 0 0 0 0 1 0 1   data bit 4 bit 5   0 1 1 0 1 1 0 1 1 0 1 0 0 0 0   check bit 4 1 0 0 0 0 1 0 1 1 1 0 0 0 0 0   2 hard
	:	*****

Fig 6 Contents of EMU's stack containing initial occurrence of each error type.

the syndrome word that represents the hard error. These hard error syndromes are stored as shown in Fig 6, which also shows the storage of a hard check bit error at address 6D HEX.

#### Two hard

An ECC "no-error" flag, following a double complement correct cycle, indicates an initial error condition of two hard errors. Data following the second complement are correct; since no error exists, a syndrome word of all zeros is generated. The EMU will store the error address, the tag bits, and the contents of the temporary register. Tag bits will be given a value of 11, indicating a doublebit hard error. The stored syndrome word is then XORed with the contents of the temporary syndrome register and the new syndrome word from the ECC device (as with a one soft/one hard error condition), and the stack pointer is incremented. In this example, the information obtained from a double-bit hard error at address 84 HEX, including a syndrome word of 101000, is stored. A 2-bit error indicating syndrome word provides no information regarding the location of the errors. Errors in data bit locations 13 and 15, for example, produce the stored syndrome word as would errors in check bit locations 3 and 5. Fig 6 illustrates the contents of the associative stack portion of the EMU following the first occurrence of each type of error discussed. Word 5 in the stack represents the double-bit hard error.

#### Logging the errors

As errors occur at new addresses, error data are stored in the stack and the stack pointer is incremented. When information is entered in stack word 15 a "stack full" flag is set. The stack full flag directs the pointer to the lowest word address location in the stack containing the value 00 in the tag bit field. After storing data, the stack pointer goes to the next highest word address location that contains a 00 in the tag bit field. The stack contains the most recent error addresses at which single-bit soft errors occurred and all addresses at which firm or hard errors occurred. When no tag bit field contains 00, the "overflow" flag is provided and no additional stack storage occurs. However, logged error information is available to the system. One of the DP8400 modes, for example, allows data to be provided to the syndrome input/output ports and output through the data input/ output ports, a capability that allows the error information to be dumped to the system disk for an additional level of storage. In another mode, the DP8400 can internally transfer data from the data input to the syndrome output, allowing the stack to be loaded from the system disk via the data bus.

Error locations are stored in real time by the logging procedure. Error resolution is defined by the correspondence of the memory address bits to the EMU address inputs. The EMU described here has eight address inputs that allow chip level error resolution in a 1M-byte memory system when 64k-bit dynamic random access memories are used. Since the EMU does not monitor the least significant eight memory address lines, error information specifically the address and syndromes as stored in the EMU-represents a memory chip location. If a "read error" match occurs, only the tag bits and/or the stored syndrome word may be updated. Therefore, each unique error address can exist in a single stack location. Each stored word location defines one defective bit (chip) location if the syndrome word indicates a single-bit error. In some cases, the error information will represent two hard errors, which normally cannot be located.

#### Relocating the errors

In response to new error information, it may be desirable to change the error locations as defined by the syndrome words stored in the EMU. If a single-bit error is accompanied by an address match and tag bits representing a stored single-bit soft error, but if the syndrome comparison indicates that a different bit is in error, the

Stored Error	Tags	Detected Error
1 bit, firm	01	1 soft, 1 hard
1 bit, hard	10	1 soft, 1 hard
1 bit, soft	00	1 soft, 1 hard
1 bit, soft	00	2 soft
1 bit, firm	01	2 hard
1 bit, hard	10	2 hard
1		
l		

Fig 7 Errors for syndrome injection in order of probability. Syndrome injection in the DP8400 allows faster correction than double complement method.

syndrome field of the matching stack word should be changed to the new syndrome word. The ECC will correct the single-bit error in the normal manner, and the most recent soft error information for that memory address will be maintained. Previous soft error information can be offloaded to a secondary storage device prior to the update.

#### Maintenance help

Maintenance tools are a by-product of the EMU system. During the ECC procedure, error locations are identified and error types determined. EMU generated flags, which are provided when the stack contents reach a defined level, allow the error information to be offloaded to the system disk and the EMU to be cleared and reloaded with selected error information from disk. After the error information is loaded on disk, the system can be powered-down for maintenance. Following system power-up, suspect information about error location may be written to the EMU. This extended logging capability is part of the total error management system.

#### Redefinition

When a single-bit error occurs in a location at which a single-bit error has occurred previously, and the stored syndrome word is the same as the single-bit error indicating syndrome word generated by the ECC device, it may be necessary to redefine the error type. If the match provides tag information indicating a soft error (tag field = 00), the tag field will be changed to 01 to indicate a single-bit firm error. Such a redefinition is valid. For instance, a firm error may be an unproved hard error or an error-prone memory device sensitive to alpha particles, system noise, or both. Such an error can be treated as either a soft error or a hard error, or be given a definition based on the present error. For the purpose of this discussion, a firm error will be treated as a hard error.

With...double complement correct cycles, 100% of 2-bit errors can be corrected when...one of the errors is hard, regardless of...error history.

Although a soft error can occur in any given location within a chip, a second soft error is most likely to occur within the same chip. Error-prone chips are identified and tagged as firm error locations. In the EMU, both the syndromes and the address field are compared, providing higher error resolution within a word. In this EMU, the tag bit field is updated and the syndrome field is rewritten (if the second error is not in the same chip, the most recent single-bit error location in that word will be stored). The ECC device corrects the single-bit error in the normal manner.

#### Double-bit error: subsequent occurrence

When a double-bit error occurs and the EMU obtains a match, the contents of the tag bit field dictate the possible courses of action (Fig 7). If the tag bits are 11, for example, a double complement correct cycle is the only option. If the tag bits indicate a single-bit hard error location, a double complement correct cycle could be implemented. On the other hand, it is reasonable to

assume that the stored syndrome word represents one of the two present error locations; in that case the error can be corrected without additional memory cycles.

### One hard-one soft, one hard

If a match is obtained, tag bits are 10, and a 2-bit error has been detected, it is most likely that one error is soft and the other hard. Syndrome injection will obtain the fastest correction. The syndrome word in the stack, which usually represents the hard error location, is presented to the DP8400. There it is XORed with the internally generated syndrome word to provide the resulting soft error syndrome word, which is then presented to the syndrome decoder. After the ECC device corrects the soft error, it generates new check bits and zero syndromes. XORing the new syndromes with the stillinjected hard error syndrome word, the unit decodes the hard error location and corrects the second error. This procedure allows correction of 2-bit errors without additional memory cycles, once the location of the hard error has been determined. Although a firm error is treated as a hard error, it must be given special consideration during system maintenance.

#### One soft-one soft, one hard

If a 2-bit error is detected and a match obtained with a tag of 01, the highest probability is that one error is soft and one is hard. The syndrome word from the stack is injected into the DP8400, where it is XORed with the internally generated syndrome word, providing the result to the syndrome decoder. Correcting the soft error, the ECC device generates new check bits and syndromes, XORs the new syndromes with the still-injected hard error syndrome word provided by the EMU, decodes the known error location, and corrects it. When the location of one error has been determined, this procedure allows high speed correction of 2-bit errors without additional memory cycles.

#### One soft-two soft

If a match is obtained, tag bits are 01, and a 2-bit error is detected, both errors are probably soft and can be corrected by syndrome injection. The syndrome word in the stack (which often represents one of the soft error locations) is presented to the DP8400, where it is XORed with the syndrome word, generated internally to provide the unknown soft error syndrome word to the syndrome decoder. Correcting the soft error, the ECC device generates new check bits and zero syndromes. XORing the new syndromes with the still-injected "known" soft error indicating syndrome word, it decodes the error location and corrects the second error. Thus, two soft errors can be corrected if the location of one is known.

#### One firm or hard-two hard

If two hard errors occur at an address where a single-bit hard error has been recorded previously, syndrome injection will usually accomplish the correction. The syndrome word in the stack, which most likely represents one of the hard error locations, is presented to the DP8400 where it is XORed with the internally generated syndrome word, providing the result to the syndrome decoder. The ECC device corrects the first error and generates new check bits and zero syndromes. XORing the new syndromes with the still-injected "known"

error indicating syndrome word, the unit corrects the second error. This procedure allows high speed correction of two hard errors when the location of one is known.

## **Double complement**

The double complement error correction cycle is effective for locating hard errors in an error management system. This technique is effective when speed of error correction is of less concern than system integrity. Use

Stored Error	Tags	Detected Error
1 bit, soft	ÒO	2 hard
1 bit, firm	01	2 soft
1 bit, hard	10	2 soft
1		

Fig 8 Errors for double complement correction. When speed is of less priority, double complement method allows more precise error detection, logging, and correction.

of the double complement correct cycle following the detection of every error enhances error determination and correction. Immediate determination of single-bit hard errors improves the possibility that double-bit errors

in the same defined address can be corrected. The next level of error detection and correction efficiency, using the double complement correct cycle for each detected error, includes those error types noted in Fig 8.

#### One soft-two hard

A no-error indication from the ECC device following the double complement correct cycle will complete the definition of the error type—defined as a 2-bit error by the syndrome word stored in the temporary syndrome register—as a 2-bit hard error. If a match occurs but the tag bit field indicates a single-bit soft error, the tag bit field can be changed to 11, indicating two hard errors, and the syndrome field replaced with the contents of the temporary syndrome register. Error information can be offloaded to a secondary storage device before this update.

## One firm or hard-two soft

If the ECC device generates error flags indicating a double-bit error at the conclusion of the double complement correct cycle, the 2-bit error that instigated the cycle remains and contains two soft errors. Since the only recorded error at the current memory location is hard, the errors are not recoverable and system operation terminates. In some systems, a firm error may be defined as a soft error, and data may be recovered. When offloading of soft errors is practiced, the disk or other storage mechanism can be interrogated for prior memory errors at the current address. These soft errors can be corrected if proper information is available.

#### Two hard-double error

When a match occurs and the tag bits indicate that an earlier 2-bit error has been recorded for the present memory address, ECC device's error flags identify the error type after the double complement correct cycle. If the present error is soft, system operation must be terminated—assuming that no additional relevant information regarding errors at this address is available from other sources. If the second set of error flags indicates that the present error is a 2-bit hard error, the errors can be corrected. Comparing the syndrome words in the temporary syndrome register and the stack will provide additional information. If the syndrome words do not match, three or four hard errors exist and system operation must be terminated.

## Locating two hard errors

When the presence of two hard errors has been determined, a subsequent access at the same address will most likely indicate a single-bit error. If the single-bit error is in one of the two locations that had defined the previous 2-bit hard error, adequate information is available to locate the other error. The temporary syndrome register will store the single-bit error indicating syndrome word. Data are corrected by the double complement correct cycle, and the syndrome word in the stack can be replaced by the contents of the temporary syndrome register. The double-bit hard error indicating syndrome word can be offloaded and the word replaced. The new word will then be offloaded and XORed with the first syndrome word, keeping the result in the secondary storage element. Secondary storage is available for interrogation if additional errors occur in the same address. In more sophisticated error management systems, additional tag bits are made available in the EMU stack. One of these tag bits can be used to indicate that additional error information exists in secondary storage for that error address.

#### Summary

The simplified error management system presented here allows correction of double-bit errors if one of the errors has previously occurred. With the use of double complement correct cycles, 100% of 2-bit error correction is provided when at least one of the errors is hard, regardless of previous error history. Enhanced error logging is provided with error type determination capability. Maintenance aids are provided through the DP8400's bidirectional data transfer capability between the syndrome input/output and data input/output ports.

# Dynamic Memory Support PRELIMINARY

# **DP84300 Programmable Refresh Timer**

# **General Description**

The DP84300 programmable refresh timer is a logic device which produces the desired refresh clock required by all dynamic memory systems.

Additional circuitry has been included in the device to minimize logic required by memory systems to perform refresh control.

# **Features**

- One chip solution to produce RFCK timing for the DP8408 and DP8409 dynamic RAM controllers
- Programmable refresh clock timer allows for a maximum refresh period with most system clocks
- Timing is completely synchronous with the input clock, preventing race conditions present in some memory controllers
- Includes a refresh request output, simplifying the design of refresh logic in discrete controllers

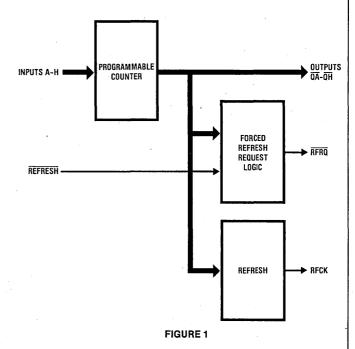
# **Connection Diagram**

#### Dual-In-Line Package

# CLOCK 24 2 23 ΠA 22 QC 20 αD 19 ΩĒ DP84300 QF ũG QH RFSH 15 ĈĒ 11 GND 13 **TOP VIEW**

Order Number DP84300N-3 See NS Package N24C

# **Block Diagram**



# Recommended Operating Conditions (Commercial)

	Min	Тур	Max	Units
V <sub>CC</sub> , Supply Voltage	4.75	5.00	5.25	٧
I <sub>OH</sub> , High Level Output Current			- 3.2	mΑ
I <sub>OL</sub> , Low Level Output Current			16	mA.
T <sub>A</sub> , Operating Free Air				
Temperature	0		75	°C

# Electrical Characteristics over recommended operating temperature range

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	High Level Input Voltage		2			V
V <sub>IL</sub>	Low Level Input Voltage				0.8	٧
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>I</sub> = - 18 mA			- 1.5	٧
V <sub>OH</sub>	High Level Output Voltage	$V_{CC} = Min, V_{IH} = 2V, V_{IL} = 0.8V, I_{OH} = Max$	2.4			Ņ
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC} = Min, V_{IH} = 2V, V_{IL} = 0.8V, I_{OL} = Max$			0.5	V
I <sub>OZH</sub>	Off-State Output Current High Level Voltage Applied	$V_{CC} = Max, V_{IH} = 2V, V_O = 2.4V, V_{IL} = 0.8V$			100	μА
I <sub>OZL</sub>	Off-State Output Current Low Level Voltage Applied	$V_{CC} = Max, V_{IH} = 2V, V_O = 0.4V, V_{IL} = 0.8V$			- 100	μА
i <sub>l</sub>	Input Current at Maximum Input Voltage	$V_{CC} = Max, V_1 = 5.5V$			1.0	mA
l <sub>IH</sub>	High Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 2.4V			25	μА
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max, V <sub>1</sub> = 0.4V			- 250	μА
Ios	Short Circuit Output Current	V <sub>CC</sub> = Max	- 30		- 130	mA
Icc	Supply Current	V <sub>CC</sub> = Max		150	180	mA

# DP84300-3 Switching Characteristics over recommended ranges of temperature and $V_{\text{CC}}$

Symbol	Paramo	eter	Conditions $R_L = 667\Omega$	TA	I 5°C 5%	Units	
				Min	Тур	Max	7
t <sub>PD</sub>	Clock to Output		C <sub>1</sub> = 45 pF		15	25	ns
t <sub>PZX</sub>	Pin 13 to Output Enable		- OL = 45 pr		15	25	ns
t <sub>PXZ</sub>	Pin 13 to Output Disable		C <sub>L</sub> = 5 pF		15	25	ns
t <sub>PZX</sub>	Input to Output Ena	ble	C <sub>L</sub> = 45 pF		25	35	ns
t <sub>PXZ</sub>	Input to Output Disa	ıble	C <sub>L</sub> = 5 pF		25	35	ns
t <sub>W</sub>	Width of Clock	High		25			ns
		Low		25			ns
t <sub>su</sub>	Set-Up Time			35			ns
t <sub>H</sub>	Hold Time			0	- 15		ns

# **Mnemonic Description**

#### INPUT SIGNALS

CLOCK Provides a time base for the programmable

divider.

A-H Program inputs A through H. These inputs select the number of clock cycles that will produce one refresh period. These inputs are binary encoded, with input A the LSB, and H the MSB. Additionally, all zeros pro-

duce the maximum count of 256, and an input of one will reset the counter to one.

REFRESH This input is used to reset the refresh request

output (RFRQ).

OE Output enable. Places the outputs in

TRI-STATE®.

CE Counter enable. This input, when low, enables the timer clock and, when high,

stalls the timer.

## **OUTPUT SIGNALS**

QA-QH Refresh timer outputs QA through QH. Timer starts at programmed input and counts

down to one.

RFRQ Refresh request. This output goes low on the rising edge of the refresh clock (RFCK). The

first input clock edge after the REFRESH in-

put is set low clears this output.

RFCK Refresh clock. The period of the clock is determined by setting conditions on input

pins A through H. This output is low for 20 clocks, and high for the remainder of the

period.

# **Functional Description**

The DP84300 block diagram is shown in Figure 1. This circuit is basically an 8-bit programmable counter. The user selects the number of input clock cycles required per refresh period and sets the binary equivalent on inputs A through H. A signal of that period is produced at the refresh clock (RFCK) output. This output stays low for 20 clock cycles, and goes high for the balance of the period.

When used with the DP8409 dynamic RAM controller, this duty cycle allows the DP8409 the maximum probability to perform a hidden refresh, while still allowing ample time for the DP8409 to perform a forced refresh when needed.

An additional output is provided to ease the design of systems that don't use the DP8409. This output is called refresh request (RFRQ). Refresh request becomes true at the rising edge of refresh clock, and becomes false on the first rising edge of the input clock after a refresh.

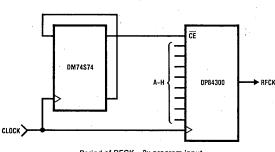
In systems where a divisor of more than 256 is needed, an expansion input ( $\overline{CE}$ ) has been provided. When this input is high, all counter-related timing is suspended. This excludes actions due to the  $\overline{REFRESH}$  input. The circuits in Figures 2a and 2b show how to expand the range of the timer by 2x or by up to 4096 clock cycles. Figures 3a and 3b show two typical applications using the DP84300.

By using the clock enable input, it is also possible to change the duty cycle of the refresh clock. The circuits in *Figures 4a and 4b* show how this may be done.

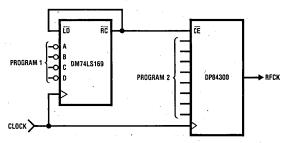
To reset the counter to a known state, select an input divisor of one. On the next clock edge the counter will reset to one. On the next clock edge whatever input divisor that is present on input A-H will be loaded into the counters.

TABLE I. DIVIDER CONSTANTS FOR GENERATION OF A 15.5  $\mu s$  CLOCK

CPU Clock Frequency	Divisor Input	Actual Period of Output	% Chance of Hidden Refresh
2 MHz	31	15.5 μs	35%
3 MHz	46	15.3 μs	56%
4 MHz	62	15.5 μs	67%
5 MHz	77	15.6 μs	74%
6 MHz	93	15.5 μs	78%
7 MHz	109	15.6 μs	81%
8 MHz	124	15.5 μs	83%
9 MHz	140	15.6 μs	85%
10 MHz	155	15.5 μs	87%



Period of RFCK = 2x program input



Period of RFCK 2 = program A × program B RFCK Is low for 20x program 1 clocks Maximum period of RFCK is 4096 clocks

FIGURE 2b. Typical Expansion for the DP84300

FIGURE 2a. Expansion of Clock Divisor by 2x

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# Functional Description (Continued)

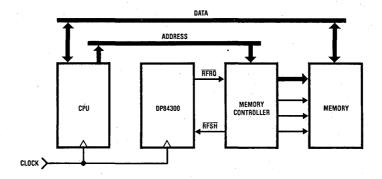


FIGURE 3a. Dynamic Memory System Using DP84300

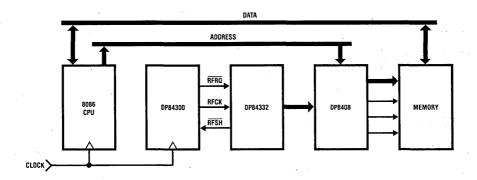


FIGURE 3b. 8086 System Using Dynamic RAMs DP8408, DP84300, and DP84332

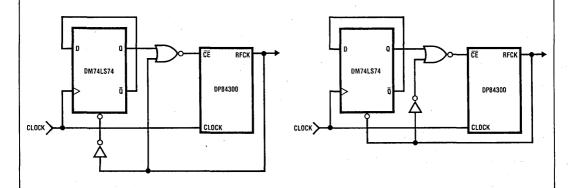
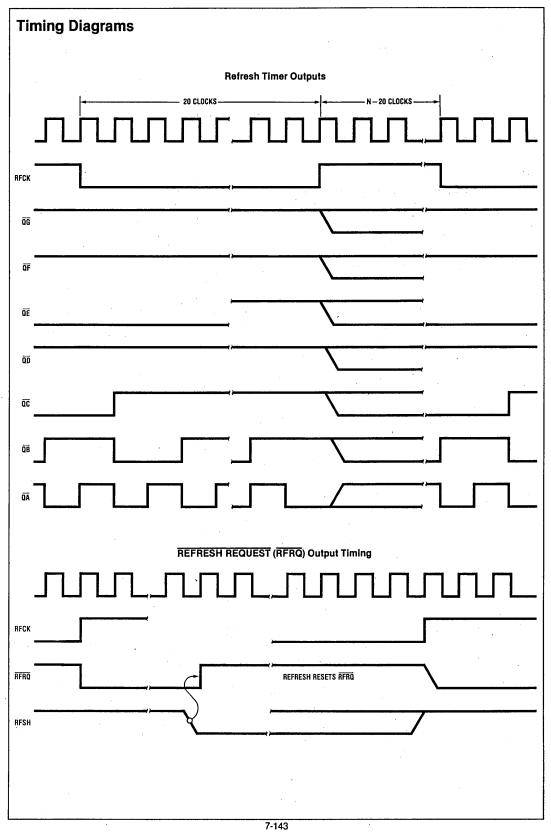


FIGURE 4a. Circuit for Extending RFCK Low to 40 Clocks

FIGURE 4b. Circuit for Extending RFCK High by 2x



# Dynamic Memory Support PRELIMINARY

# DP84312 Dynamic RAM Controller Interface Circuit for the NS16032 CPU

# **General Description**

The DP84312 dynamic RAM controller interface is a Programmable Array Logic (PAL)\* device which allows for easy interface between the DP8409 dynamic RAM Controller and the NS16032 microprocessor.

Using timing signals from the NS16201 timing and control unit and the NS16032, the DP84312 supplies all control signals needed to perform memory read, write, byte write, and refresh.

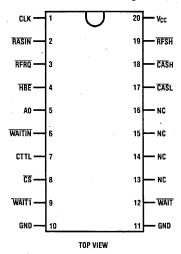
\*PAL is a registered trademark of Monolithic Memories, Inc.

# **Features**

- Low parts count memory system
- Allows the DP8409 to perform hidden refresh
- Allows for the insertion of wait states for slow dynamic RAMs
- Supplies independent CASs for byte writing
- Possibility of operation at 8MHz with no wait states
- 20-pin 0.3 inch wide package
- Standard National Semiconductor PAL part (DMPAL16R6)
- PAL logic equations can be modified by the user for his specific application and programmed into any of the PALs in the National Semiconductor PAL family, including the new high speed PALs.

# **Connection Diagram**

#### Dual-In-Line Package



Order Number DP84312N-3 See NS Package N20A

# Recommended Operating Conditions (Commercial)

	Min Typ	Max	Units
V <sub>CC</sub> , Supply Voltage	4.75 5.00	5.25	٧
I <sub>OH</sub> , High Level Output Current		- 3.2	mΑ
I <sub>OL</sub> , Low Level Output Current		24 (Note 2)	mA
T <sub>A</sub> , Operating Free Air		(14016 2)	
Temperature	0	75	°C

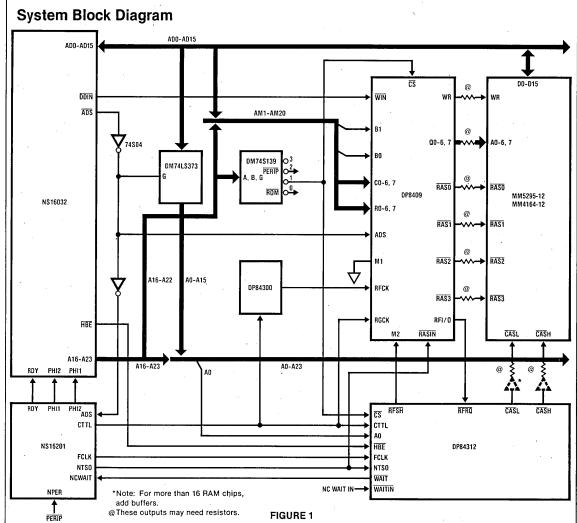
# Electrical Characteristics over recommended operating temperature range

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	High Level Input Voltage		2			٧
V <sub>IL</sub>	Low Level Input Voltage				0.8	٧
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>I</sub> = - 18 mA			<b>– 1.5</b>	V
V <sub>OH</sub>	High Level Output Voltage	$V_{CC} = Min, V_{IH} = 2V, V_{IL} = 0.8V, I_{OH} = Max$	2.4			٧
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC} = Min, V_{IH} = 2V, V_{IL} = 0.8V, I_{OL} = Max$			0.5	٧
I <sub>OZH</sub>	Off-State Output Current High Level Voltage Applied	$V_{CC} = Max, V_{IH} = 2V, V_O = 2.4V, V_{IL} = 0.8V$			100	μА
l <sub>OZL</sub>	Off-State Output Current Low Level Voltage Applied	$V_{CC} = Max, V_{IH} = 2V, V_O = 0.4V, V_{IL} = 0.8V$			- 100	μΑ
l <sub>l</sub>	Input Current at Maximum Input Voltage	$V_{CC} = Max, V_I = 5.5V$			1.0	mA
t <sub>IH</sub>	High Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 2.4V			25	μΑ
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 0.4V			- 250	μА
los	Short Circuit Output Current	V <sub>CC</sub> = Max	- 30		- 130	mA
Icc	Supply Current	V <sub>CC</sub> = Max		150	225 (Note 1)	mA

# DP84312-3 Switching Characteristics over recommended ranges of temperature and V<sub>CC</sub>

Symbol	Parameter	•	Conditions $R_L = 667\Omega$		Units		
				Min	Тур	Max	1
t <sub>WD</sub>	WAITIN to WAIT Delay		C <sub>L</sub> = 45 pF	7	25	40	ns
t <sub>PD</sub>	Clock to Output		C <sub>L</sub> = 45 pF		15	25	ns
t <sub>PZX</sub>	Pin 11 to Output E	Enable	C <sub>L</sub> = 45 pF		15	25	ns
t <sub>PXZ</sub>	Pin 11 to Output [	Disable	C <sub>L</sub> =5 pF		15	25	ns
t <sub>w</sub>	Width of Clock	High		25			ns
		Low		25			ns
t <sub>su</sub>	Set-Up Time			40			ns
t <sub>h</sub>	Hold Time			0	<b>– 15</b>	l	ns

Note 1:  $I_{CC} = \max$  at minimum temperature. Note 2: One output at a time; otherwise 16 mA.



# **Mnemonic Description**

#### INPUT SIGNALS

CTTL

CLK Clock input. This clock comes from the FCLK output of the NS16201 timing and control

unit, and supplies timing for the internal

logic.

RASIN RAS input. This input is connected to the NTSO pin of the NS16201. This signal marks

the start of a memory cycle.

RFRQ Refresh request. The DP8409 requests a

forced refresh with this input.

HBE, A0 Address select inputs. These inputs select the type of write during a write cycle, and

select their respective CAS outputs. These inputs must remain stable throughout the

memory cycle.

WAITIN This wait input allows other devices to use the NCWAIT line of the NS16201 clock chip.

System clock input. This clock is used to synchronize the memory system to the micro-

processor clock.

CS

Chip select. This input is used to determine if a memory cycle or a hidden refresh cycle is

to be performed.

WAIT1 Insert one wait state. This input allows the use of slow memories with a microprocessor

using a fast clock by inserting a wait state in selected memory cycles.

 $V_{CC}$ , GND 5.0V ± 5%.

## **OUTPUT SIGNALS**

RFSH Refresh. This output switches the DP8409 to

a refresh mode.

CAS outputs. CASH is for controlling the high bank of dynamic RAMs, while CASL

controls the CAS line of the lower bank of RAMs. If only eight RAMs are used in each bank, the CAS outputs will directly drive the memories. For larger arrays, these outputs should be buffered with a high current driver.

such as the DP84244 MOS driver.

This output controls the insertion of wait states. This output is ORed with WAITIN to allow other devices to insert wait states.

WAIT

# **Functional Description**

The DP84312 detects the start of a memory cycle when NTSO from the NS16032 timing and control unit (TCU) goes low. The NTSO signal is also used to supply RASIN to the DP8409 dynamic RAM controller. After the DP8409 has latched the row address and supplied the column address to the DRAMs, the DP84312 latches the column address. The DP84312 supplies two CAS outputs, one for the high byte of memory, and the other for the low byte. The ability to control the upper and lower bytes of memory separately is important during a memory write cycle where one byte of memory is to be written (byte write).

By connecting WAIT1 of the DP84312 to ground, all selected memory cycles will have one wait state inserted. This allows an NS16032 operating at high CPU clock frequencies to use slower dynamic RAMs.

Memory refresh may be achieved in one of two ways: hidden or forced. Hidden refresh is accomplished whenever a refresh is requested (Internal to the DP8409) and an unselected memory cycle occurs. With a hidden refresh, the DP84312 does nothing while the DP8409 performs the refresh. If no refresh has occurred before the trailing edge of refresh clock, the DP8409 will request a forced refresh. The DP84312 detects this request, and allows the current memory cycle to finish. It then outputs wait states to the CPU, which will hold the CPU if it requests a memory cycle. During this time the DP84312 has switched the dynamic RAM controller to the auto refresh mode, allowing it to perform a refresh. At the end of the refresh cycle,

the DP8409 is switched back to the auto access mode, and the wait is removed after a sufficient RAS precharge time. The total forced refresh takes four CPU clock cycles; of which some, none or all may be actual wait states. If the CPU does not request a memory cycle during this refresh cycle, the refresh will not impact the CPU's performance.

The DP84312 can possibly be operated at 8 MHz with no wait states (WAIT1 = "1") given the following conditions:

T2 + T3 = 250 ns

NTSO generation = 15 ns max.

RASIN to CAS delay DP8409-2 = 130 ns max.

External CASH, generation using 74S02 and 74S240

7.5 ns (74S02) + 10 ns (74S240) - 7.5 ns (less load on 8409  $\overline{CAS}$  line) = 10 ns max.

Transceiver delay = 12 ns max.

NS16032 data setup = 20 ns max.

∴Minimum t<sub>CAC</sub> = 63 ns

= 250 - 15 - 130 - 10 - 12 - 20

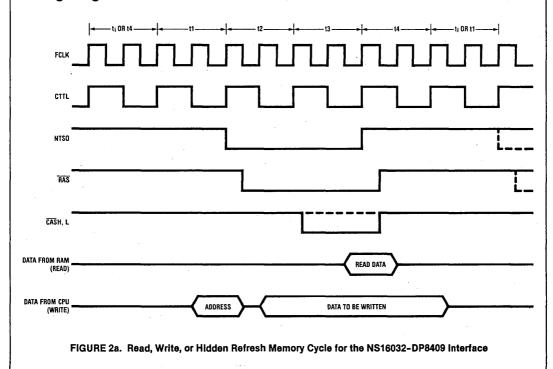
Minimum  $t_{RAS} = 250 \text{ ns}$ Minimum  $t_{RP} = 250 \text{ ns}$ 

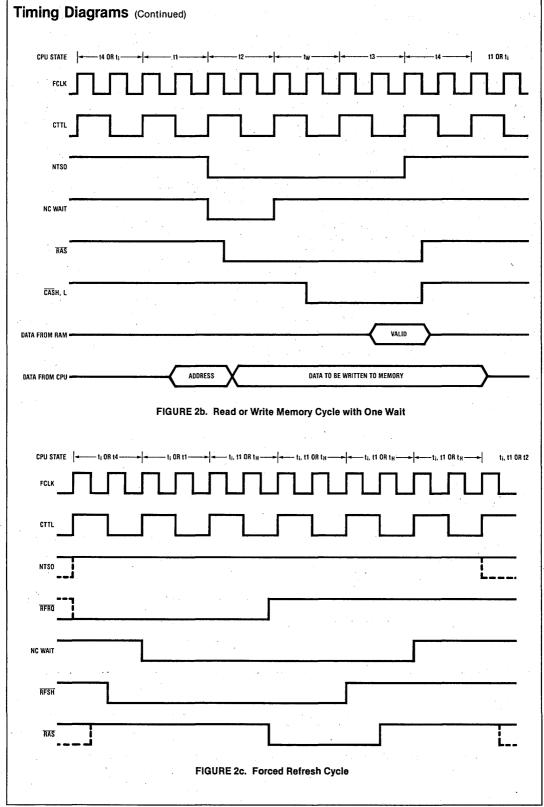
Minimum t = 20 ns

Minimum  $t_{RAH} = 20 \text{ ns}$ 

The DP84312 is a standard National Semiconductor PAL part (DMPAL16R6). The user can modify the PAL equations to support his particular application. The DP84312 logic equations, function table (functional test), and logic diagram can be seen at the end of this Data Sheet.

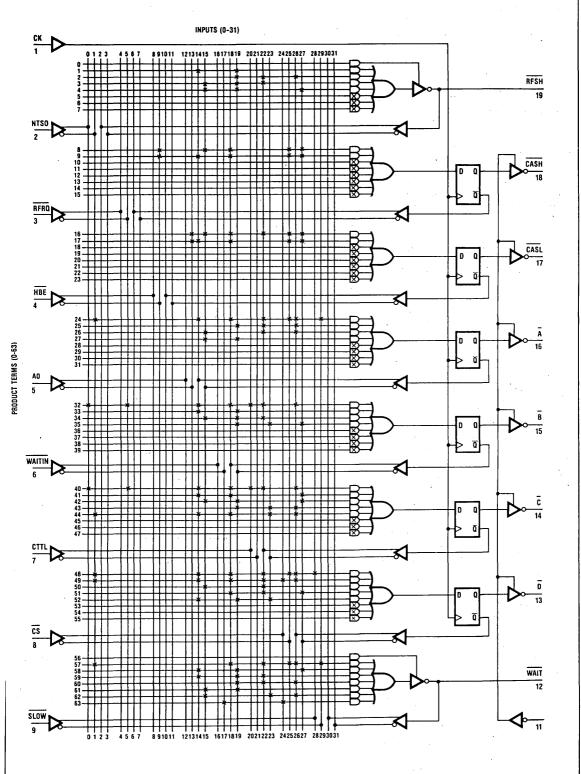
# **Timing Diagrams**





```
PAL16R6
DP84312
Interface Circuit for the NS16032/DP8409
Memory System
CK NTSO /RFRQ /HBE A0 /WAITIN CTTL /CS /SLOW
GND /OE /WAIT /D /C /B /A /CASL /CASH /RFSH VCC
CASH: = A • /B • /C • D • HBE • CS+
        /A • /B • D • HBE • CS
CASL:= A • /B • /C • D • /A0 • CS+
        /A • /B • D /A0 • CS
     :=/A • /B • /C • /D • /NTSO • CS • SLOW+
        B • /C • /D+
        A • /C • /D+
        A • B
B :=/A • /B • /C • /D • NTSO • RFRQ • CTTL+
        /A • B+
        A • B • /C+
        B • C • D
     :=/A • /B • /C • /D • NTSO • RFRQ • CTTL+
        /A • /B • D+
        A • B • D+
        B • C • /D+
        /A • /B • C • /D • /NTSO
D
     :=/A • /B • /C • /D • /NTSO • CS • /SLOW+
        /A • /B • /C • /D • /NTSO • /CS+
        A • /C+
        /B • /C • D+
        /A • B • C
IF (VCC) WAIT = /B • /C • /D • /NTSO • CS • SLOW +
        /A • B • D+
        B • /C • /D+
        A • B+
        A • C • /D+
        /CS • WAITIN
IF (VCC) RFSH = /A · B+
        B • /C • /D+
        A • B • /C+
        A • B • C
```

Fur	nction	Table	9													•	
СК	NTSO	RFRQ	HBE	A0	WAITIN	CTTL	cs	SLOW	ŌĒ	CASH	CASL	Α	В	С	D	WAIT	RFSH
С	Н	Н	L	L	Н	Н	Н	Н	L	Х	X	Х	Х	Χ	X	X	Х
С	, н	Н	· L	L	Н	Н	Н	Н	L	L	L.	L	L	L	L	L	L
С	L	Х	,L	L	H	Х	Ł	Н	L	L	L	L	L	L	Н	L	L
С	L	Х	L	L	. н	Х	Ł	Н	L	Н	Н	L	L	Н	Н	L	L
С	Х	Х	L	L	H	Х	L	н	L	H.	Н	L	L	Н	L	L	L
С	. Н	Х	L	L	н	Х	L	Н	L	L	L, L	L	Ļ	L	L	L	L
С	L '	Х	· L	Н	Н	Х	L	L.	L	L	L	Н	L	L	L	Н	L
С	Х	Х	L	Н	Н	Х	L	L	L	L	L	Н	L	L	Н	L	L
С	Х	. X	. L	Н	Η	Х	L	L	L	Н	L	L	L	L	Н	L	L
С	Х	Х	L	Н	Н	Х	L	L	L	Н	L	L	L	Н	Н	L	L
С	X	Х	L	Н	H	Х	L	L	L	Н	L	L	L	Н	L	L	L
С	н	Х	L	L	Н	Х	Н	Н	L	L	L	L	L	L	L	L	L
С	L	Х	L	L	H	Х	Н	Х	L	L	L	L,	L	L	Н	L	L
С	· X	X	L	L	L	X	Н	X.	L	L	L	L	L	Н	Н	Н	L,
С	Н	X	L	L	Н	Х	Н	· X	Ļ	L	L	L	L	Н	L	L	L
С	Н	Х	L	L	Н	X	Н	Х	L	L	L	L	L	L	L	L	Ł
С	. н	L	Х	Х	Н	Н	Х	Х	L	L	L	L	·H	Н	L	L	Ή
С	Н	Х	Х	Х	Н	L	Х	Χ `	L	L	L	L	Н	Н	Н	Н	Н
С	Н	Н	Х	Х	Н	Н	Х	Х	L	L	L	L	Н	L	Н	Н	Н
С	Н	Н	Х	Х	Н	L	Х	Х	L	L	L	L	Н	L	L	Н	Н
С	. н	Н	Х	Х	Н	Н	Х	Х	L	L	L	Н	Н	L	L	Н	Н
С	Н	Н	Х	Х	Н	L	Х	Х	L	L	L	Н	Н	L	Н	Н	Н
С	Н	Н	Х	Х	Н	H	Х	Х	L	L	L	Н	Н	Н	Н	Н	Η.
C	Н	Н	Х	Х	Н	L	Х	. X	L	L	L	H٠	Н	Н	L	Н	L
С	Н	Н	Х	Х	Н	Н	Х	Х	L	L	L	Н	L	Н	L	Н	L
С	Н	Н	Х	Х	Н ;	Х	Н	Н	L	L	L	L	L	L	L	L	L
С	L	Н	X	Х	L	Х	Н	Х	L	L	L	L	L	L	Н	Н	L
С	L	Н	Х	Χ	Ł	Х	н	Х	L	L	L	L	L	Н	Н	Н	L
С	L	Н	Х	Х	L	Х	Н	X	L	L	L	L	L	Н	L	Н	L
С	L	X	Х	Х	Н	Х	Н	X	L	L	L	L	L	Н	L	L	L
С	Н	X.	Х	Χ	Н	Х	Н	Х	L	L	L	L	L	L	L	L	L
С	н	H	Н	Н	Н	H: /	Н	Н	Н	Z	Z	Z	Z	Z	Z	Z	Z



# Dynamic Memory Support PRELIMINARY

# DP84322 Dynamic RAM Controller Interface Circuit for the 68000 CPU

# **General Description**

The DP84322 dynamic RAM controller interface is a Programmable Array Logic (PAL)\* device which allows for easy interface between the DP8409 dynamic RAM Controller and the 68000 microprocessor.

The DP84322 supplies all the control signals needed to perform memory read, write and refresh. Logic is included for inserting a wait state when using fast CPUs.

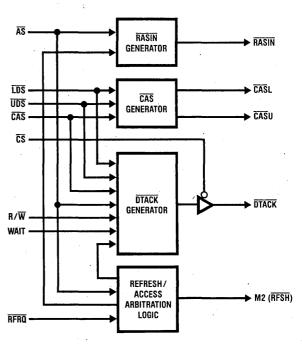
# **Features**

- Provides 3-chip solution for the 68000 CPU and dynamic RAM interface
- Works with all 68000 speed versions
- Possibility of operation at 8 MHz with no wait states
- Performs hidden refresh
- DTACK is automatically inserted for both memory access and memory refresh
- Performs forced refresh using typically 4 CPU clocks
- Standard National Semiconductor PAL part (DMPAL16R4)
- PAL logic equations can be modified by the user for his specific application and programmed into any of the PAL in the National Semiconductor PAL family, including the new high speed PAL's.

# **Connection Diagram**

#### **Dual-In-Line Package** CLOCK -20 · Vcc AS . RASIN 19 UDS -- DTACK LDS RFSH 17 R/W 16 NC RFRO 15 - NC CAS 14 CS. 13 - CASU CASL WAIT . 12 ŌĒ GND 11 **TOP VIEW**

# **Block Diagram**



<sup>\*</sup>PAL is a registered trademark of Monolithic Memories, Inc.

Order Number DP84322N-3 See NS package N20A

# Recommended Operating Conditions (Commercial)

	Min Typ	Max	Units
V <sub>CC</sub> , Supply Voltage	4.75 5.00	5.25	٧
IOH, High Level Output Current		-3.2	mA
I <sub>OL</sub> , Low Level Output Current		24	mA
		(Note 2)	
T <sub>A</sub> , Operating Free Air	•		
Temperature	0	75	°C

# Electrical Characteristics over recommended operating temperature range

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	High Level Input Voltage		2			٧
VIL	Low Level Input Voltage				0.8	٧
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>I</sub> = - 18 mA			- 1.5	٧
VoH	High Level Output Voltage	$V_{CC} = Min, V_{IH} = 2V, V_{IL} = 0.8V, I_{OH} = Max$	2.4			٧
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC} = Min, V_{IH} = 2V, V_{IL} = 0.8V, I_{OL} = Max$			0.5	٧
l <sub>OZH</sub>	Off-State Output Current High Level Voltage Applied	$V_{CC} = Max, V_{IH} = 2V, V_O = 2.4V, V_{IL} = 0.8V$	ration (Cristian State) And Cristian		100	μΑ
l <sub>OZL</sub>	Off-State Output Current Low Level Voltage Applied	$V_{CC} = Max, V_{IH} = 2V, V_O = 0.4V, V_{IL} = 0.8V$			- 100	μΑ
11	Input Current at Maximum Input Voltage	$V_{CC} = Max, V_1 = 5.5V$	·		1.0	mA
I <sub>IH</sub>	High Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 2.4V			25	μΑ
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 0.4V			- 250	μА
los	Short Circuit Output Current	V <sub>CC</sub> = Max	- 30		- 130	mA
Icc	Supply Current	V <sub>CC</sub> = Max		150	225 (Note 1)	. mA

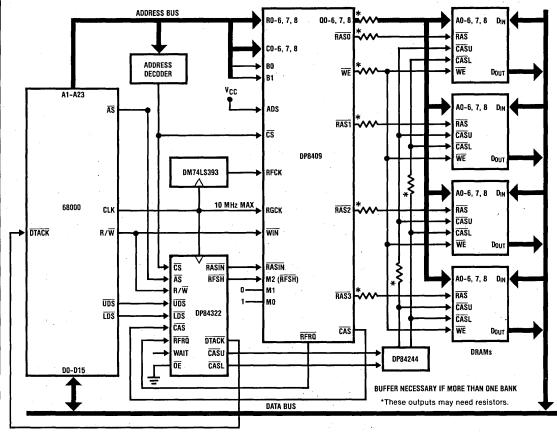
# Switching Characteristics over recommended ranges of temperature and $V_{\text{CC}}$

Symbol	Paramete	r	Test Conditions R <sub>L</sub> =667Ω		Units		
				Min	Тур	Max	1
t <sub>PD</sub>	Input to Output		C 45 pF		25	40	ns
t <sub>PD</sub>	Clock to Output		$C_L = 45 \text{ pF}$		15	25	ns
t <sub>PZX</sub>	Pin 11 to Output Enable				15	25	пѕ
t <sub>PXZ</sub>	Pin 11 to Output	Disable .	C <sub>L</sub> =5 pF		15	25	ns
t <sub>PZX</sub>	Input to Output E	nable	C <sub>L</sub> =45 pF		25	40	ns
t <sub>PXZ</sub>	Input to Output D	isable	C <sub>L</sub> = 5 pF		25	40	ns
t <sub>w</sub>	Width of Clock	High		25			ns
		Low		25			ns
t <sub>su</sub> .	Set-Up Time			40			ns
th	Hold Time			0	- 15		ns

Note 1:  $I_{CC} = \max$  at minimum temperature. Note 2: One output at a time; otherwise 16 mA.

# **System Block Diagram**

# DP84322 and DP8409 for 68000 CPU



# **Mnemonic Description**

## INPUT SIGNALS

WAIT

INPUT SIGI	NALS .	OUTPUT SI	GNALS .
CLOCK	The clock signal determines the timing of the outputs and should be connected directly to the 68000 clock input.	RASIN	This output provides a memory cycle start signal to the DP8409 and provides RAS timing during hidden refresh.
ĀS	Address Strobe from the 68000 CPU. This input is used to generate RASIN to the DP8409.	CASU, CASL	These signals are the separate CAS outputs needed for byte writing.
UDS, LDS	Upper and lower data strobe from the 68000 CPU. These inputs, together with AS, R/W, provide DTACK to the 68000.	DTACK	This output is used to insert wait states into the 68000 memory cycles when selected and during a forced refresh cycle where the CPU
R/W	Read/write from the 68000 CPU, when WAIT=0. Selects processor speed when WAIT=1 ("1" = 4 to 6 MHz, "0" = 8 MHz).		attempts to access the memory. This output is enabled when $\overline{\text{CS}}$ input is low and TRI-STATED when $\overline{\text{CS}}$ is high.
CAS	Column Address Strobe from the DP8409. This input, together with LDS and UDS, provides two separate CAS outputs for accessing upper and lower memory data bytes.	RFSH	This output controls the mode of the DP8409. It always goes low for 4 CPU clock periods when $\overrightarrow{AS}$ is inactive and a forced refresh is requested through $\overrightarrow{RFRQ}$ input. This allows the
<del>CS</del>	Chip Select. This input enables DTACK output. CS = 0, DTACK output is enabled; CS = 1, DTACK output is TRI-STATE®.	÷	DP8409 to perform an automatic forced refresh.
RFRQ	Refresh Request. This input requests the DP84322 for a forced refresh.		

This input allows the necessary wait state to be inserted for memory access cycles.

## **Functional Description**

#### **MEMORY ACCESS**

As a 68000 bus cycle begins, a valid address is output on the address bus A1-A23. This address is decoded to provide Chip Select (CS) to the DP8409. After the address becomes valid, AS goes low and it is used to set RASIN low from the DP84322 interface circuit. Note that CS must go low for a minimum of 10 ns before the assertion of RASIN for a proper memory access. As an example, with a 8 MHz 68000, the address is valid for at least 30 ns before AS goes active. AS then has to ripple through the DP84322 to produce RASIN. This means the address is valid for a minimum of 40 ns before RASIN goes low, and the decoding of CS should take less than 30 ns. At this speed the DM74LS138 or DM74LS139 decoders can be selected to guarantee the 10 ns minimum required by CS set-up time going low before the access RASIN goes low (t<sub>CSRL</sub> of the DP8409). This is important because a false hidden refresh may take place when the minimum t<sub>CSRL</sub> is not met. Typically RASIN occurs at the end of S2. Subsequently, selected RAS output, row to column select and then CAS will automatically follow RASIN as determined by mode 5 of the DP8409. Mode 5 guarantees a 30 ns minimum for row address hold time (t<sub>RAH</sub>) and a minimum of 8 ns column address set-up time (t<sub>ASC</sub>). If the system requires instructions that use byte writing, then CASU and CASL are needed for accessing upper and lower memory data bytes, and they are provided by the DP84322. In the DP84322, LDS and UDS are gated with CAS from the DP8409 to provide CASL and CASU, therefore designers need not be concerned about delaying CAS during write cycles to assure valid data being written into memory. The 8 MHz 68000 specifies during a write cycle that data output is valid for a minimum of 30 ns before DS goes active. Thus, CASL and CASU will not go low for at least 40 ns after the output data becomes stable, guaranteeing the 68000 valid data is written to memory.

Furthermore, the gating of UDS, LDS and CAS allows the DP84322 interface controller to support the test and set instruction (TAS). The 68000 utilizes the read-modify-write cycle to execute this instruction. The TAS instruction provides a method of communication between processors in a multiple processor system. Because of the nature of this instruction, in the 68000, this cycle is indivisible and the Address Strobe AS is asserted throughout the entire cycle, however DS is asserted twice for two accesses: a read then a write. The dynamic RAM controller and the DP84322 respond to this read-modify-write instruction as follows (refer to the TAS instruction timing diagram for clarification). First, the selected RAS goes low as a result of AS going low, and this RAS output will remain low throughout the entire cycle. Then the DP84322's selected CAS output (CASL or CASU) goes low to read the specified data byte. After this read, DS goes high causing the selected CAS to go high. A few clocks later R/W goes low and then DS is reasserted. As DS goes low, the selected CAS goes low strobing the CPU's modified data into memory, after which the cycle is ended when AS goes high.

The two  $\overline{\text{CAS}}$  outputs from the DP84322, however, can only drive one memory bank. For additional driving capability, a memory driver such as the DP84244 should be added to drive loads of up to 500 pF.

Since this DP84322 interface circuit is designed to operate with all of the 68000 speed versions, a status input called WAIT is used to distinguish the 8 MHz from the others. The

WAIT input should be set low for 6 MHz or less allowing full speed of operation with no wait states. Data Transfer Acknowledge input (DTACK) of the 68000 at these speeds is automatically inserted during S2 for every memory transaction cycle and is then negated at the end of that cycle when UDS and/or LDS go high. For the 8 MHz 68000 however, a wait state is required for every memory transaction cycle. At these speeds, the WAIT input is set high, selecting the DP8409's CAS output to generate DTACK and again DTACK is negated at the end of the cycle when UDS or LDS goes high. Note that DTACK output is enabled only when the DP8409's CS is low. Therefore when the 68000 is accessing I/O or ROM (in other words, when the DP8409 is not selected), the DP84322's DTACK output goes high impedance logic '1' through the external pull-up resistor and it is now up to the designer to supply DTACK for a proper bus cycle.

The following table indicates the maximum memory speed in terms of the DRAM timing parameters:  $t_{CAC}$  (access-time from  $\overline{CAS}$ ) and  $t_{RP}$  ( $\overline{RAS}$  precharge time) required by different 68000 speed versions:

Microprocessor Clock	Maximum t <sub>CAC</sub>	Minimum t <sub>RP</sub>	Minimum t <sub>RAS</sub>
8 MHz	125 ns	140 ns	220 ns
6 MHz	90 ns	170 ns	290 ns
4 MHz	270 ns	280 ns	450 ns

Pin 5 ( $R/\overline{W}$  input to the DP84322) is not used as  $R/\overline{W}$  when the WAIT input is high. Therefore, when WAIT is high and pin 5 is low, this is configured for the 8 MHz 68000. The dynamic RAM controller in this configuration operates in mode 5 and mode 1.

When both WAIT and pin 5 are high, this is configured for 4 MHz and 6 MHz 68000, allowing only two microprocessor clocks for memory refresh. Furthermore, the designer can use the DP8408 because the dynamic RAM controller now operates in mode 0 and mode 5 or mode In addition, the programmable refresh timer, DP84300, should be used to determine the refresh rate (RFCK) and to provide the refresh request (RFRQ) input to the DP84322. The refresh timer can provide over two hundred different divisors. RFRQ is given at the beginning of every RFCK cycle and remains active until M2 goes low for memory refresh. The DP84322 samples RFRQ when AS is high, then sets M2 low for two microprocessor clocks, taking the DP8408 or DP8409 to the external control refresh mode. RASIN for this refresh is also issued by the DP84322. If a memory access is pending, RASIN for this access will not be given until it is delayed for approximately one microprocessor clock, allowing RAS precharge time for the dynamic RAMs.

The following table indicates different memory speeds in terms of the DRAM parameters required by 4 MHz and 6 MHz 68000:

Microprocessor Clock	Maximum t <sub>CAC</sub>	$\begin{array}{c} \text{Minimum} \\ \textbf{t}_{\text{RAS}} \end{array}$	Minimum t <sub>RP</sub>	Minimum t <sub>RAH</sub>
4 MHz	290 ns	200 ns	225 ns	20 ns
6 MHz	110 ns	125 ns	140 ns	20 ns

DP8408, DP8409 operate in mode 6 and mode 0.

### Functional Description (Continued)

When WAIT=1, pin 5=0 (8 MHz), the PAL controller supports read and write cycles with one inserted wait state, forced refresh with five wait states inserted if  $\overline{CS}$  is valid, and hidden refresh. This PAL mode does not support the TAS instruction.

When WAIT=pin 5=1 (4-6 MHz), the PAL controller supports read and write cycles with no wait states inserted, and forced refresh with two wait states inserted if  $\overline{CS}$  is valid. This PAL mode does not support the TAS instruction and only supports hidden refresh when used in mode 5 with the DP8409 controller.

The DP84322 can possibly be operated at 8 MHz with no wait states (WAIT = "0") given the following conditions:

FAST PAL (PAL16R4A)

\$2+\$3+\$4+\$5=\$250 ns

\$\overline{AASIN}\$ delay = \$60 ns (\$\overline{AS}\$ low max.)

+25 ns (Fast PAL delay) = \$5 ns max.

\$\overline{AASIN}\$ to \$\overline{CAS}\$ delay DP8409-2 = 130 ns max.

External \$\overline{CASH}\$, generation using 74S02

and 74S240

7.5 ns (74S02) + 10 ns (74S240) - 7.5 ns (less load on 8409 \$\overline{CAS}\$ line) = 10 ns max.

Transceiver delay (74LS245) = 12 ns max.

68000 data setup into \$6 = 40 ns min.

∴ Minimum \$\text{tacc}\$ delay \$\overline{CAC}\$ = 53 ns

= 250 - 85 - 130 - 10 - 12 + 40

Minimum \$\text{tacc}\$ taccompage = 240 ns

Minimum \$\text{tacc}\$ taccompage = 150 ns

#### REFRESH CYCLE

Minimum  $t_{RAH} = 20 \text{ ns}$ 

Since the access sequence timing is automatically derived from RASIN in mode 5, R/ $\overline{C}$  and  $\overline{C}$ ASIN are not used and now become Refresh Clock (RFCK) and RAS-generator clock (RGCK) respectively. The Refresh Clock RFCK may be divided down from RGCK, which is the microprocessor clock, using the DM74LS393 or DM74LS390. RFCK provides the refresh time interval and RGCK the fast clock for all-RAS refresh if forced refreshing is necessary. The DP8409 offers both hidden refresh in mode 5 and forced refresh in mode 1 with priority placed on hidden refreshing. Assume 128 rows are to be refreshed, then a 16  $\mu s$  maximum clock period is needed for RFCK to distribute refreshing of all the rows over the 2 ms period.

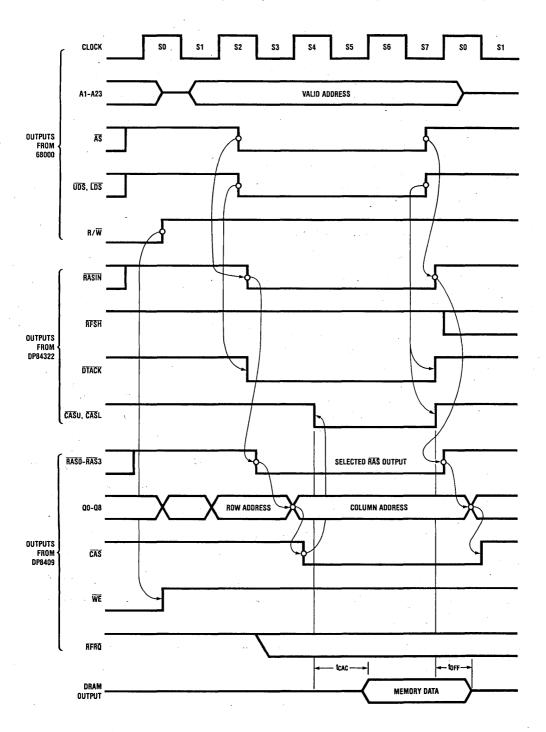
The DP8409 provides hidden refreshing in mode 5 when the refresh clock (RFCK) is high and the microprocessor is not accessing RAM. In other words, when the DP8409's chip select is inactive because the microprocessor is

accessing elsewhere, all four RAS outputs follow RASIN, strobing the contents of the on-chip refresh counter to every memory bank. RASIN going high terminates the hidden refresh and also increments the refresh counter, preparing it for the next refresh cycle. Once a hidden refresh has taken place, a forced refresh will not be requested by the DP8409 for the current RFCK cycle.

However, if the microprocessor continuously accessed the DP8409 and memory while RFCK was high, a hidden refresh could not have taken place and now the system must force a refresh. Immediately after RFCK goes low, the Refresh Request signal (RFRQ) from the DP8409 goes low, indicating a forced refresh is necessary. First, when RFRQ goes low any time during S2 to S7, the controller interface circuit waits until the end of the current memory. access cycle and then sets M2 (RFSH) low. This refresh takes four microprocessor clocks to complete. If the current cycle is another memory cycle, the 68000 will automatically be put in four wait states. Alternately, when RFRQ goes low while AS is high during S0 to S1, M2 is now set low at S2. Therefore, it requires an additional microprocessor clock for this refresh. Once the DP8409 is in mode 1 forced refresh, all the RAS outputs remain high until two RGCK trailing edges after M2 goes low, when all RAS outputs go low. This allows a minimum of one and a half clock periods of RGCK for RAS precharge time. As specified in the DP8409 data sheet, the RAS outputs remain low for two clock periods of RGCK. The refresh counter is incremented as the RAS outputs go high. Once the forced refresh has ended, M2 is brought high, the DP8409 back to mode 5 auto access. Note that RASIN for the pending access is not given until it has been delayed for a full microprocessor clock, allowing RAS precharge time for the coming access.

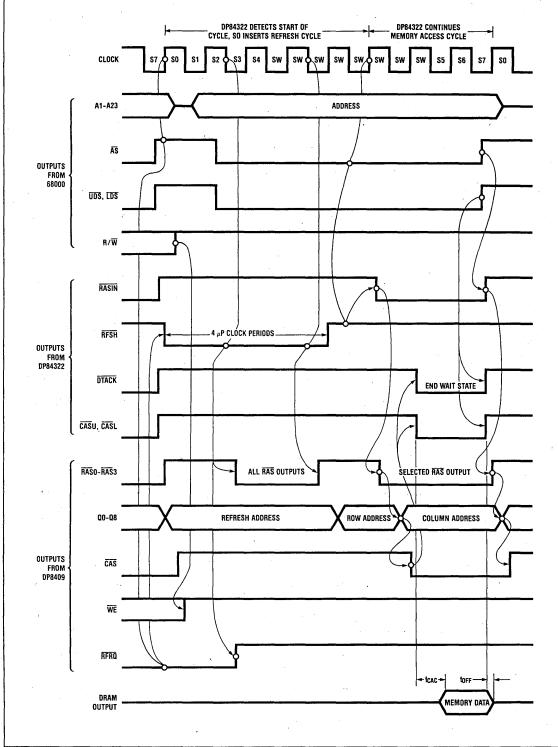
If the 68000 bus is inactive (i.e., the 68000's instruction queue is full, or the 68000 is executing internal operations such as a multiply instruction, or the 68000 is in halt state...) and a refresh has been requested, a refresh will also take place because  $\overline{\text{RFRQ}}$  is continuously sampled while  $\overline{\text{AS}}$  is high. Therefore, refreshing under these conditions will be transparent to the microprocessor. Consequently, the system throughput is increased because the DP84322 allows refreshing while the 68000 bus is inactive.

The 84322 is a standard National Semiconductor PAL part (DMPAL16R4). The user can modify the PAL equations to support his particular application. The 84322 logic equations function table (functional test), and logic diagram can be seen at the end of this data sheet.



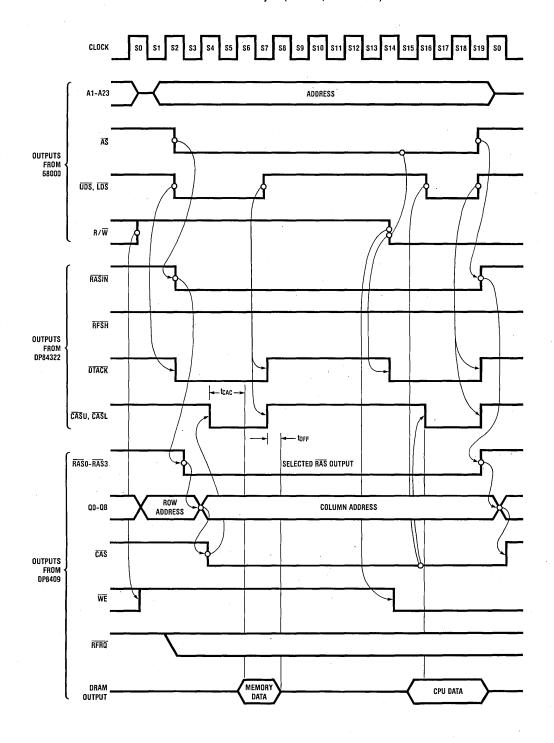
## Timing Diagrams (Continued)

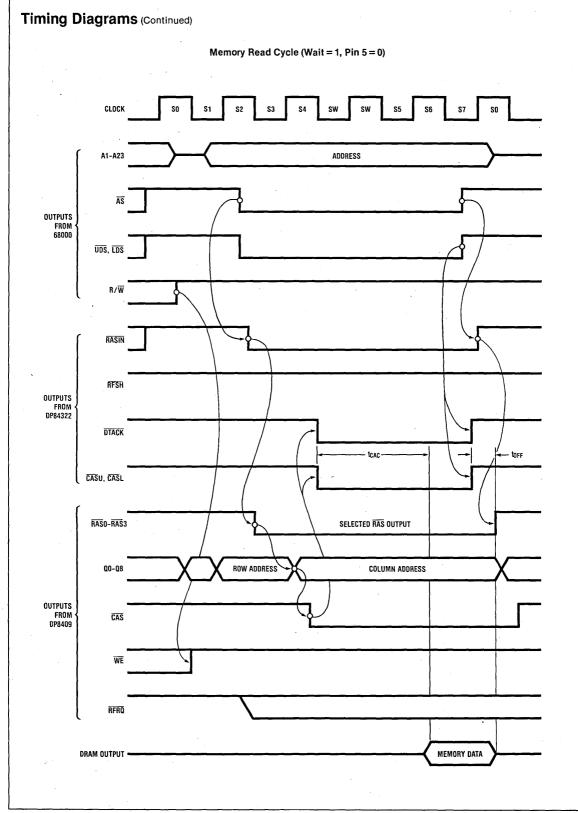
68000 Memory Read Cycle and Forced Refresh (Wait = 0, Pin 5 =  $R/\overline{W}$ ) (4 wait clock periods inserted for forced refresh)



### TAS Instruction Cycle (Wait = 0, Pin $5 = R/\overline{W}$ )

Timing Diagrams (Continued)

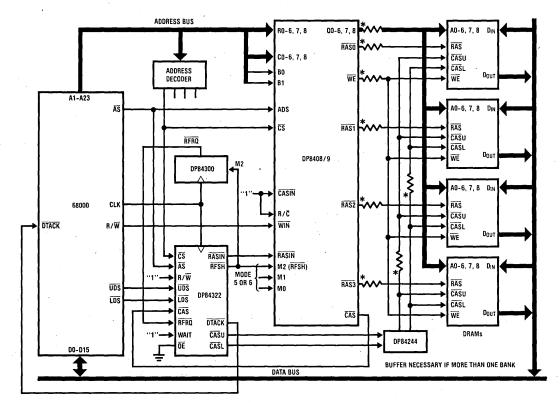




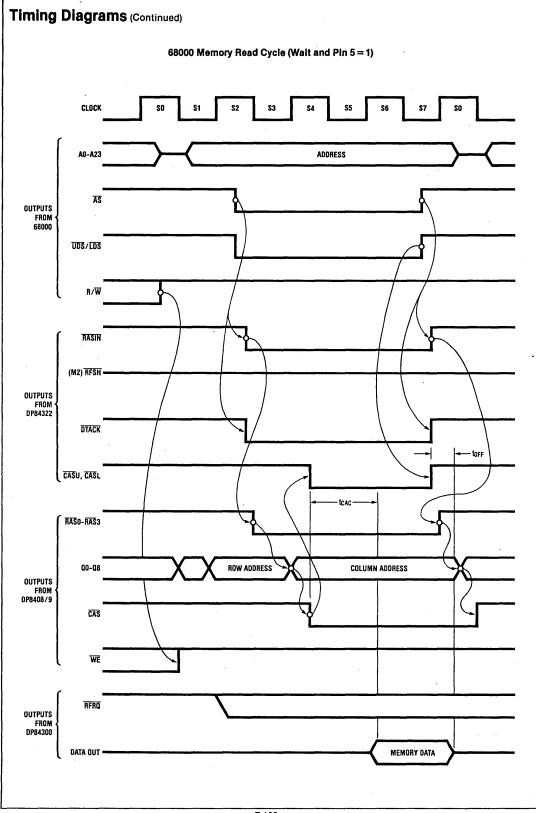
## Timing Diagrams (Continued) Memory Read Cycle and Forced Refresh (Wait = 1, Pin 5 = 0) DP84322 DETECTS START OF CYCLE, SO INSERTS REFRESH CYCLE DP84322 CONTINUES MEMORY ACCESS CYCLE CLOCK A0-A15 ADDRESS ĀS OUTPUTS FROM 68000 UDS, LDS RASIN 4 μP CLOCK PERIODS RFSH OUTPUTS FROM DP84322 DTACK CASU, CASL RASO-RAS3 ALL RAS OUTPUTS SELECTED RAS OUTPUT ROW ADDRESS COLUMN ADDRESS REFRESH ADDRESS Q0-Q8 CAS OUTPUTS FROM DP8409 WE ŔFŔŎ MEMORY DATA OUTPUT

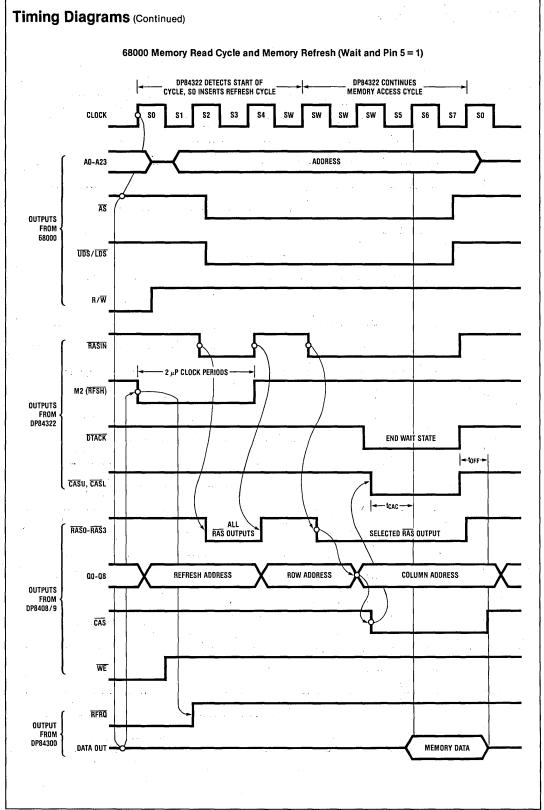
## **Modified System Block Diagram**

#### DP8408, DP8409 and 68000 Interface



<sup>\*</sup>These outputs may need resistors.





```
PAL16R4
DP84322
Dynamic RAM Controller Interface for the
MC68000-DP8409 Memory System
CK /AS /UDS /LDS R /RFRQ /CAS /CS WAIT GND
/OE /CL /CU /C /B /A /RFSH /DTACK /RASIN VCC
IF (VCC) RASIN = AS • /RFSH • /A +
RFSH • R • A • WAIT
```

IF (CS) DTACK = /R • CAS • WAIT + UDS • /A • /B • /WAIT + LDS • /A • /B • /WAIT + AS • /R • /A • /B • /WAIT + AS • /RFSH • R • /A • /B • WAIT

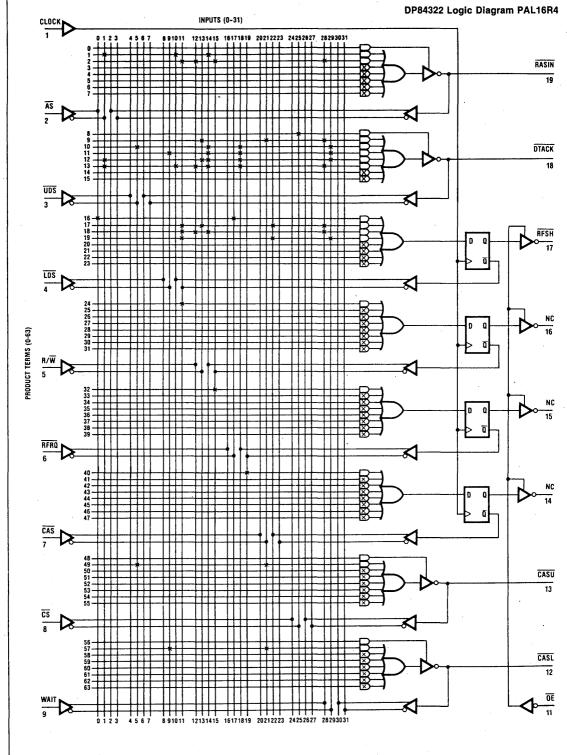
RFSH • /C • /WAIT
A := RFSH

B: = A C:= B

IF (VCC) CU = UDS • CDS IF (VCC) CL = LDS • CAS

## **Function Table**

· ui	iou.	,,,	DIC														
СК	ĀS	UDS	LDS	R	RFRQ	CAS	CS	WAIT	ŌĒ	CL	CU	C	B	Ā	RFSH	DTACK	RASIN
С	Н	L	L	Н	Н	Н	Н	L.	L	Н	Н	Х	X	Х	Х	X	Н
C	H.	L	L	Н	Н	L	Н	L '	L	L	L	Χ	Χ	Х	Х	X	Н
С	Н	L	н	Н	Н	L	Н	L	L	Н	L.	Х	Х	Х	Х	Х	Н
С	Н	Η.	L	Н	Н	L	Н	L	L	L	Н	Χ	Х	Х	X	Х	H
С	Н	н	Н	Н	Н	Н	Н	L	L	· H	Н	H	Н	Н	Н	Z	Н
С	L	L	Н	Н	· H	Н	L	L	L	Н	Н	Н	Η,	Н	Н	, L	· L
С	L.	L	н	Н	Н	L	L	L	L	Н	L	Н	Н	Н	H	L	L
С	L	Н	Н	Н	Н	L.	L	L	L	Н	Η.	Н	Н	Н	H	Н	L
С	L	Н -	- H	L	н	L	·L	L	L	н	H	Н	Н	Н	Н	L	L
С	L.	L	H	L	Н	L	Ĺ	Ŀ	L	Н	L	Н	Н	Н	Н	L	L
С	Н	Н	. н	L	Н	Н	L	Ŀ	L.	Н	Н	Н	Н	Ή	H	н .	н
С	н	Н	Н	L.	' L	Н	L	L	L	Н	Н	Н	Н	Н	L	Н	Н
С	Н	Н	Н	L	L	н	L	L	L	Н	Н	Н	Н	L	L.	·H	Η,
С	L	Н	L	L	Н	H"	L	L	L	Н	Η.	Н	L	L	L	H.	Н
С	L	н	L	L	н	н	L	L	L	Н	Н	L	L	L	L	н	Н
С	L	Н	L	L	Н	H	L	L	L	Н	Н	L	L	L	H	Н	Н
С	L	Н	L	L	Н	·н	L	L	L	Н	Н	L	L	H	H	H	L
С	L	Н	L	L	Н	L	L	L	L	L	Н	L	Η.	Н	Н	L	L
С	L	Н	L	L	Н	L	L	L	L	L	Н	Н	Н	Н	н	L	L
С	н	Н	н	L	Н	L	L	L	L	Н	Н	Н	н	Н	н	Н	Н
С	Н	H	Н	L	L	Н	L	Н .	Ł	H :	Н	Н	Н	Н	L	• н	Н
С	н	Н	Н	L	L	Н	L	н	L.	Н	Н	Н	Н	L	L	Н	н
С	L	L	L	L	н	Η .	. L	н	L	Н	Н	Н	L	L	L	н	Н
C.	L	L	L	L	Н	.² H	L	Н	Ĺ	Н	Н	Ŀ	L	L	· L	Н	Н
C ·	L.	L	Ĺ	L	Н	н	L	н	L	H-	H-	L	L	L	Н	Н	Н
С	· L	L	L	L	н	Н	L	н	Ľ	Н	Н	L	L	Н	Н	. н	L
С	L	L	L	L	н	L	L	н	L	L	L	L	н	H	Η.	L	L
С	н	Н	Н	L	Ĥ	L	L	н	L.	Н	Н	H	Н	Н	Н	. L	Н
C.	н	Н	H	L	н	Н	Н	Н	L	Н	Н	H	Н	Н	н	Z	Н
С	Н	Н	Н	Н	L	Н	L	H	Ĺ	H	H	Н	Н	Н	L	Н	H
С	Н	Н	Н	Н	Ĺ	Η.	Ĺ	H	Ĺ.	H	. H	Н	Н	L	L	H	L
Ċ	L	L	н	Н	Н	Н	L	H	Ĺ	H	Н	Н	L	Ĺ	H	H	H
Č	Ĺ	L	Н	H	H	Н	Ĺ	H	Ē	H	н	Ĺ	Ĺ	H	H	H	Ĺ
Č	Ē.	Ĺ	H	H	H	Ĺ	Ĺ	H	Ē	Н	L	Ē	H	Н	H	L	Ē
č	H	H	H	Н	H	Ē	٠Ē	H	ī	H	H	H	Н	Н	H	H	н
Č	Н	H				Ĥ	Ē						z		Z		H
			H	н	H	H		н	H	н	н	ż		z		H	



# Dynamic Memory Support PRELIMINARY

## DP84332 Dynamic RAM Controller Interface Circuit for the 8086 and 8088 CPUs

## **General Description**

The DP84332 dynamic RAM controller interface is a Programmable Array Logic\* (PAL) device which allows for easy interface between the DP8408 dynamic RAM controller and the 8086 and 8088 microprocessors. No wait states are required for memory access. Memory refreshing may be hidden (no wait states) or forced (up to three wait states).

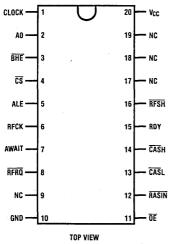
The DP84332 supplies all the control signals needed to perform memory read, write, and refresh. Logic is also included to insert a wait state when using slow memory.

## **Features**

- Low parts count controller for the DP8408/DP8409
- Works with 8086 systems configured in min or max mode
- Performs hidden refresh using the DP8408 dynamic RAM controller
- Compatible with both the 8086 and 8088 microprocessors
- Capable of working at all CPU clock frequencies up to 8 MHz
- Standard National Semiconductor PAL part (DMPAL16R8)
- PAL logic equations can be modified by the user for his specific application and programmed into any of the PALs in the National Semiconductor family, including the new high speed PALs.

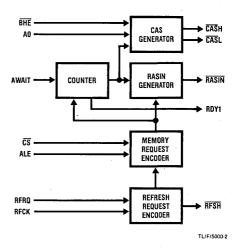
## **Connection Diagram**

## Dual-In-Line Package



Order Number DP84322N-3 NS Package Number N20A

## **Block Diagram**



<sup>\*</sup>PAL is a registered trademark of Monolithic Memories, Inc.

## Recommended Operating Conditions (Commercial)

	Min Typ	Max	Units
V <sub>CC</sub> , Supply Voltage	4.75 5.00	5.25	٧
IOH, High Level Output Current		-3.2	mΑ
IOL, Low Level Output Current		24	mΑ
		(Note 2)	
T <sub>A</sub> , Operating Free Air	0	75	۰.

## Electrical Characteristics over recommended operating temperature range

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	High Level Input Voltage		2			٧
V <sub>IL</sub>	Low Level Input Voltage				0.8	V
V <sub>IC</sub>	Input Clamp Voltage	$V_{CC}^{\dagger} = Min, I_I = -18 \text{ mA}$			1.5	٧
V <sub>OH</sub>	High Level Output Voltage	$V_{CC} = Min, V_{IH} = 2V, V_{IL} = 0.8V, I_{OH} = Max$	2.4			٧
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC} = Min, V_{IH} = 2V, V_{IL} = 0.8V, I_{OL} = Max$			0.5	٧
l <sub>ozh</sub>	Off-State Output Current High Level Voltage Applied	$V_{CC} = Max, V_{IH} = 2V, V_O = 2.4V, V_{IL} = 0.8V$			100	μΑ
l <sub>OZL</sub>	Off-State Output Current Low Level Voltage Applied	$V_{CC} = Max, V_{IH} = 2V, V_{O} = 0.4V, V_{IL} = 0.8V$			- 100	μΑ
l <sub>i</sub>	Input Current at Maximum Input Voltage	$V_{CC} = Max, V_1 = 5.5V$			1.0	mA
l <sub>IH</sub>	High Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 2.4V			25	μΑ
lįL	Low Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> = 0.4V			- 250	μΑ
los	Short Circuit Output Current	V <sub>CC</sub> = Max	- 30		- 130	mA
Icc	Supply Current	V <sub>CC</sub> = Max		150	225 (Note 1)	mA

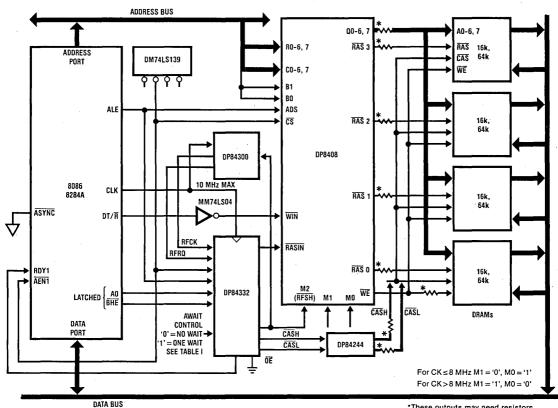
## DP84332-3 Switching Characteristics over recommended ranges of temperature and $V_{CC}$

Symbol	Paramete	r	Conditions $R_L = 667\Omega$	T <sub>A</sub>	Units		
				Min	Тур Мах		1
t <sub>PD</sub>	Clock to Output	$C_L = 45 \text{ pF}$	C <sub>L</sub> = 45 pF		15	25	ns
t <sub>PZX</sub>	Pin 11 to Output En	able	C <sub>L</sub> = 45 pF		15	25	ns
t <sub>PXZ</sub>	Pin 11 to Output Dis	sable	$C_L = 5 pF$		15	25	ns
t <sub>W</sub>	Width of Clock	High		25		1.	ns
••		Low		25			ns
t <sub>su</sub>	Set-Up Time			40			ns
t <sub>H</sub>	Hold Time			0	<b>– 15</b>		ns

Note 1:  $I_{CC} = \max$  at minimum temperature. Note 2: One output at a time; otherwise 16 mA.

## System Block Diagram

#### Interfacing the DP8408 to an 8086 System



\*These outputs may need resistors.

## **Mnemonic Description**

#### **INPUT SIGNALS**

CF

ALE

**RFCK** 

**AWAIT** 

RFRQ

CLOCK The CLOCK signal determines the timing of the outputs and should be connected directly to the 8086 clock.

AO, BHE These inputs come from the 8086 CPU. They must remain stable during the memory cycle for proper operation of the CAS outputs.

Chip enable. This input is used to select the memory and enable the hidden refresh logic.

Address latch enable. This input is used to indicate the beginning of a memory cycle.

> Refresh clock. The period of this input determines the refresh interval. The duty cycle of this clock will determine the length of time that the circuit will attempt a hidden refresh.

When connected to  $V_{CC}$ , the DP84332 will insert an extra wait state in selected memory

cycles.

Refresh request. This input' requests the DP84332 to perform a refresh. The state of the RFCK input will determine what type of refresh will be performed.

#### **OUTPUT SIGNALS**

**RDY** 

**RFSH** 

RASIN This output provides a memory cycle start signal to the DP8408, and provides RAS timing during refresh.

CASH, These signals are the separate CASs needed CASL for byte writing. Their presence is controlled by BHE and A0 respectively.

> This output is used to insert a wait state into the 8086 memory cycles when selected and during a forced refresh cycle where the 8086 attempts to access the memory. The 8284A clock circuit should be configured so that ASYNC is enabled.

This output controls the mode of the DP8408 dynamic RAM controller. When low, it switches the DP8408 into an all RAS refresh mode. This signal is also used to reset the refresh request logic.

## **Functional Description**

A memory cycle starts when chip select ( $\overline{\text{CS}}$ ) and address latch enable (ALE) are true. RASIN is supplied from the DP84332 to the DP8408 dynamic RAM controller, which then supplies a RAS signal to the selected dynamic RAM bank. After the necessary row address hold time, the DP8408 switches the address outputs to the column address. The DP84332 then supplies the required  $\overline{\text{CAS}}$  signals ( $\overline{\text{CAS}}$ H,  $\overline{\text{CASL}}$ ) to the RAM. For byte operations, only one  $\overline{\text{CAS}}$  will be activated. To differentiate between a read and a write, the DT/ $\overline{\text{R}}$  signal from the CPU is inverted and supplied by the DP8408 to the memory array.

A refresh cycle is started by one of two conditions. One is when a refresh is requested (RFRQ is true), refresh clock (RFCK) is high, and a non-selected memory cycle is started (CE is not true, ALE is high). This is called hidden refresh because it is transparent to the CPU. In this case, the address supplied to the memories comes from the refresh counter in the DP8408, and no CAS signals are generated from the DP84332. The second form of refresh occurs when a refresh is requested, refresh clock is low, and there is no memory cycle in progress. This is called forced refresh, because the CPU will be forced to wait during the next memory cycle to allow for the refresh to be performed. In this case, a refresh is performed as before, but any attempt to access memory is delayed by wait states until after the refresh is finished. In either case, the refresh request is cleared by the refresh line (RFSH) which also goes to the DP8408.

In a standard memory cycle, the access can be slowed down by one clock cycle to accommodate slower memories. This extra wait state will not appear during the hidden refresh cycle, so faster devices on the CPU bus will not be affected.

With higher speed systems, memory speed requirements will affect the performance of the system. Table I shows memory speed requirements at three different CPU clock speeds.

**TABLE I. MEMORY SPEED REQUIREMENTS** 

CPU	t <sub>C</sub>				
Clock Frequency	No Wait States	1 Wait State	t <sub>RAH</sub>		
8 MHz	≤ 105 ns	≤223 ns	≤30 ns		
5 MHz	≤ 170 ns	≤370 ns	≤30 ns		

 $t_{CAC}$  = access time from  $\overline{CAS}$  including delay through buffers (DP84244)  $t_{BAH}$  = row address hold time from  $\overline{RAS}$ 

### **System Description**

For memory operation, the DP84332 can be directly connected between the control signals from the CPU chip set and the DP8408 dynamic RAM controller. Each CAS output of the DP84332 is capable of driving eight memory devices. If additional drive is required, a DP84244 buffer can be used to increase the fanout to the full capabilities of the DP8408 (eight memories per output of the DP84244).

The 84332 is a standard National Semiconductor PAL part (DMPAL16R8). The user can modify the PAL equations to support his particular application. The 84332 logic equations, function table (functional test) and logic diagram can be seen at the end of this data sheet.

## **Refresh Request Logic**

To generate the refresh request for the DP84332, external circuitry is required. Figure 1 shows how this can be implemented, using standard SSI and MSI logic. A DM74LS393 counter is used to time the period between refresh cycles, while the DM74LS74 flip-flop is used to record the need of a new refresh. A better solution is to use the 24-pin DP84300 programmable refresh timer, as shown in Figure 2. This part allows a maximum amount of time for a hidden refresh to occur before lowering the refresh clock output, and implements the refresh request logic.

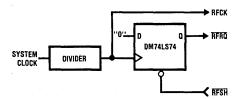


FIGURE 1. Using a Flip-Flop and a Counter for Refresh Request Logic

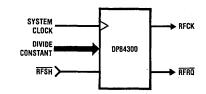
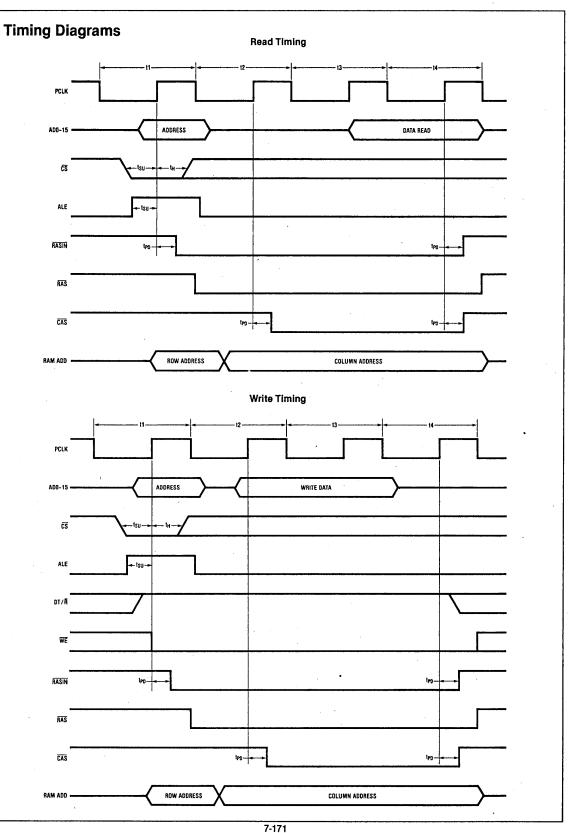
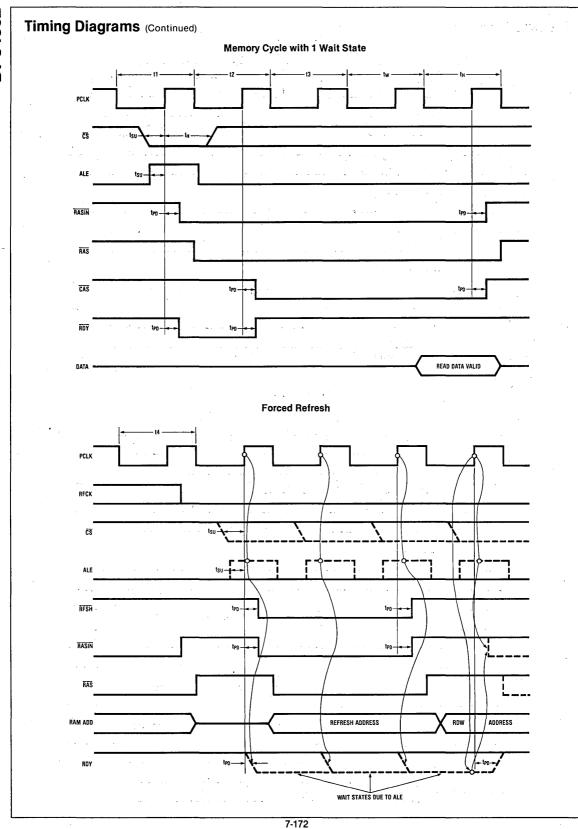


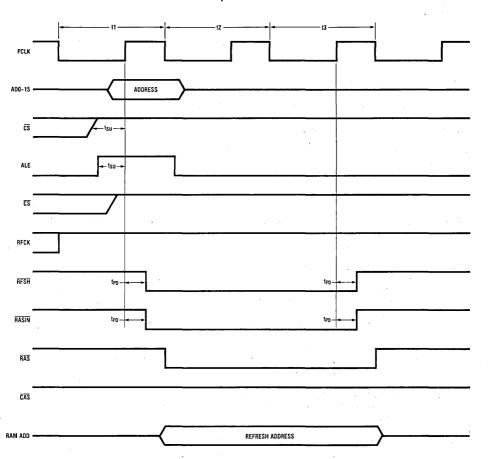
FIGURE 2. Using the DP84300 Refresh Counter for Refresh Request Logic







### Transparent Refresh



16R8
DP84332
Dynamic RAM Controller Interface for the 8086-8408 System
CK A0 /BHE /CS ALE RFCK WAIT /RFRQ NC GND /OE /RASIN /CA /CB
RDY /RFSH /A /B /MRQ VCC

MRQ:= /RASIN • /CA • /CB • RDY • /RFSH • /A • /B • /MRQ • RFRQ • CS • ALE • /RFCK + MRQ • RASIN + RASIN • /CA • /CB • RDY • RFSH • /A • /MRQ • CS • ALE

B:= RASIN • /CA • /CB • RFSH • /A • /B + RASIN • /CA • /CB • /RDY • /RFSH • /A • /B • WAIT + RASIN • RDY • /RFSH • A • /B

A:= RASIN • /CA • /CB • RDY • /RFSH • /A • /B • /WAIT+ RASIN • RDY • /RFSH • /A • B+ RASIN • RDY • /RFSH • A • /B

RFSH:= /RASIN • /CA • /CB • RDY • /RFSH • /A • /B • /MRQ • RFRQ • /CS • ALE • RFCK + /RASIN • /CA • /CB • RDY • /RFSH • /A • /B • /MRQ • RFRQ • /RFCK + RASIN • /CA • /CB • RFSH • /A • /B

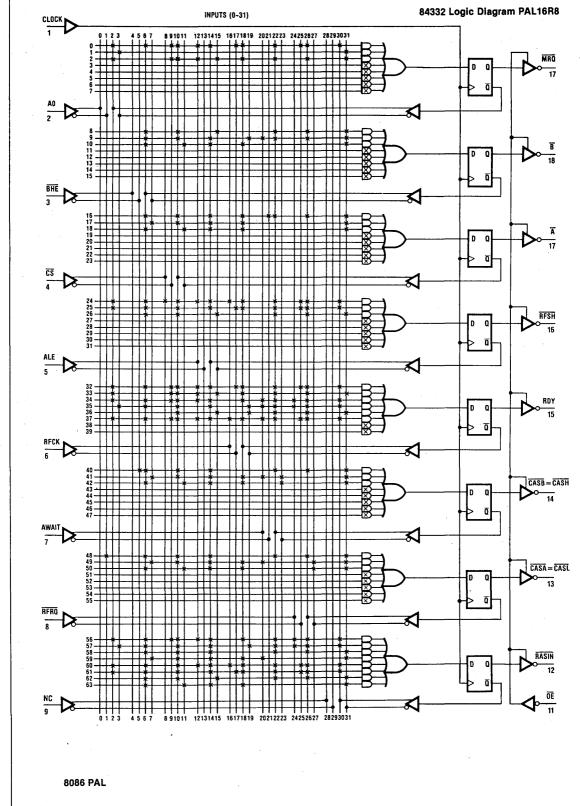
/RDY:= /RASIN • /CA • /CB • RDY • /RFSH • /A • /B • MRQ • RFRQ • CS • ALE • /RCFK + RASIN • /CA • /CB • RDY • RFSH • /A • /MRQ • CS • ALE + /RASIN • /CA • /CB • RDY • /RFSH • /A • /B • /MRQ • /RFRQ • CS • ALE • WAIT + /RASIN • /CA • /CB • /RDY • /RFSH • /A • /B • MRQ • /RFRQ • WAIT + RASIN • /CA • /CB • /RDY • RFSH • /A + /B • /MRQ • RFRQ • CS • ALE • RFCK • WAIT + /RASIN • /CA • /CB • RDY • /RFSH • /A • /B • /MRQ • RFRQ • CS • ALE • RFCK • WAIT

CB:= RASIN • /CA • /CB • /RFSH • /A • /B • BHE + RASIN • CB • RDY • /RFSH • /A • B • WAIT + RASIN • CB • RDT • /RFSH • A • /B

CA:= RASIN • /CA • /CB • /RFSH • /A • /B • /A0 + RASIN • CA • RDY • /RFSH • /A • B • WAIT + RASIN • CA • RDY • RFSH • A • /B

RASIN: = /RASIN • /CA • /CB • RDY • /RFSH • /A • /B • /MRQ • /RFRQ • CS • ALE + /RASIN • /CA • /CB • /RDY • /RFSH • /A • /B • MRQ • /RFRQ + RASIN • /CA • /CB • /RFSH • /A • /B + RASIN • RDY • /RFSH • /A • B • WAIT + /RASIN • /CA • /CB • RDY • /RFSH • /A • /B • /MRQ • RFRQ • ALE • RFCK + /RASIN • /CA • /CB • RDY • /RFSH • /A • /B • /MRQ • RFRQ • /RFCK + RASIN • /CA • /CB • RFSH • /A • /B + /A • /B • /MRQ • RFRQ • /RFCK + RASIN • /CA • /CB • RFSH • /A • /B + /A • /B • /ASIN • RDY • /RFSH • A • /B

Fu	ncti	on Ta	able													
СК	A0	BHE	CS	ALE	RFCK	WAIT	RFRQ	ŌĒ	RASIN	CA	CB	RDY	RFSH	Ā	B	MRQ
С	L	L	Н	L	Н	L	Н	L	Х	Х	Х	Х	Х	Х	Х	Х
С	L	L	Н	L	H	L	Н	L	H	Н	Н	Н	Н	Н	Н	H
O O	X	X	L	H	X	L	Н	L	Ļ	H L	Н	H H	H	H	H	H
C	L L	H	L L	L	X X	L L	H H	L	L	L	H	Н	Н	L L	L	Н
C	X	X	H	Ĺ	Ĥ	Ľ.	H	ī.	н	H	H	H	H	н	H	H
Č	x	x	Ë	Ĥ	×	H	н	Ĺ	Ë	H	H	Ë	Ĥ	Н	Н	H
С	Н	Н	Ĺ	L	X	Н	Н	L	L	Н	Н	Н	Н	Н	L	н
С	Н	Н	L	L	Х	Н	Н	L	L	Н	Н	H	Н	L	Н	Н
С	Н	Н	L.	L	X	н	Н	L	L	Н	Н	Н	Н	L	L	Н
С	Х	Х	H	L	Н	Н	Н	L	H	H	Н	Н	H	Н	Н	Н
CC	X	X	H	Н	H X	. х х	L X	L	L L	H H	H	H H	L. L	H	H	H
C	x	x	Х	L L	x	X	Ĥ	Ĺ	н	Н	Н	Н	H	H	·Н	Н
Č	x	â	x	Ē	Ĺ	x	Ë	Ē	. Ľ	H	н	·н	Ĺ	н	H	H
Č	x	X	X	Ē	x	x	x	Ē	Ĺ.	H	H	H	Ĺ	н	L	H
С	Х	Х	Х	L	Х	X	Н	L	Н	Н	Н	Н	Н	Н	Н	н
С	X	Х	L	Н	L	Х	L	L	L	Н	Н	L	L	Н	Н	L
С	Н	L	L	L	X	Х	Х	L	Ļ	Н	Н	L	L	Н	L	L
C	Н	L	L	L	Х	X	Н	Ļ	H	Н	Н	L	Н	Н	Н	L
CC	H H	L L	L	L	X X	L	H	L	L L	H H	H L	H ·	H H	H. L	H	H
C	Н	L	L	·L	x	L	H	Ŀ	Ĺ	Н	Ĺ	Н	H	Ŀ	L	Н
C	X	X	Ē	Ĺ	x	Ĺ	H	ī.	н	H	H	H	н	H	H	H
Č	x	x	x	Ē	Ĺ	×	L.	Ĺ	Ë	н	Ĥ	H	Ĺ	H	H	н
С	Χ	Х	L	Н	Х	Н	Х	L	L.	Н	Н	L	L	Н	L	L
С	L	L	L	L	Х	Н	Х	L	Н	Н	H	Ļ	Н	Н	Н	L
С	L	L	L	L	X	Н	Н	L	L	Н	Н	L	• Н	Н	H	Н
С	L	L	Ļ	L	X	Н	Н	L	L	Ļ	L	Н	Н	H	L	Н
CC	L	L L	L	L L	X	H H	H	L	L L	L L	L L	H H	H H	L	H	H
C	X	X	L	L	x	Н	Н	Ĺ	н	H	H	H	Н	н	H	H
Č	x	x	Ĺ	H	Ĥ	Ľ	Ë	Ē	Ë	H	H	H	н	H	H	H
Č	Ĥ	Ĺ	Ē	Ĺ	X	Ē	×	Ē	Ĺ	Ĥ	L	Н	H	L	Н	н
C	·H	L	L	L	X	L	, X	L	. L	Н	L	н.	. H	L	L	н
С	Х	Х	L	L.	X	L	X	L	H	Н	Н	H	Н	Н	Н	Н
С	Х	X	L	H	Н	Н	L .	L	L	H	H	L	H	H	H	H
<u>C</u>	Х	, X ,	L	L	X	X	X	Н	Z	Z	Z		Z	Z	Z	Z



# Interfacing the DP8408/09 To Various Microprocessors

National Semiconductor Application Note AN-309 Chuck Pham June 1982



High storage density and low cost have made dynamic RAMs the designer's choice in most memory applications. However, the major drawback of dynamic RAMs is the complex timing involved. First, a RAS must occur with the row address previously set up on the multiplexed address bus. After the row address has been held for some minimum time after RAS (namely the row address hold time of the dynamic RAMs, t<sub>RAH</sub>), the column address is set up and then CAS occurs. In addition, refreshing must be done periodically to keep all memory cells charged.

With the introduction of the DP8408 Dynamic RAM Controller/Driver, the above complexities are simplified. The DP8408 is housed in a 48-pin package with eight multiplexed address outputs (Q0-7) and six control outputs (RAS0-3, CAS, WE). It consists of two 8-bit address latches and an 8-bit refresh counter. All the output drivers are capable of driving 500 pF loads.

The following discussion demonstrates a typical application of the DP8408 Dynamic RAM Controller/Driver in Z8000™— and Z80®-based systems. The DP8408 basically has six modes of operation: Externally Controlled Refresh, Externally Controlled Access, Auto Access (slow t<sub>RAH</sub>), Auto Access (fast t<sub>RAH</sub>) and Set End of Count.

The DP8408, operating in the auto access mode, requires only RASIN to initiate a memory access cycle because all the dynamic RAM's control signals are automatically delayed from this input. (Refer to Figure 1 for the auto access timing sequence.)

In the following applications, the DP8408 operates in either mode 5 or mode 6 Auto Access and mode 1 or 2 Externally Controlled Refresh to provide minimum additional logic.

#### The DP8408 and Z8000 Interface

#### Memory Access Cycle:

Figure 2a shows the detailed block diagram of the Z8000 and the DP8408 interface. Consider a memory cycle of the Z8000; first, the memory address is output on the Address and Data multiplexed bus (AD0-15) during T1 and is latched to the DP8408 by  $\overline{\rm AS}$ . Simultaneously,  $\overline{\rm MREQ}$  goes low and is used to provide  $\overline{\rm RASIN}$  to initiate a memory transaction cycle. Then the selected  $\overline{\rm RAS}$  output, row address hold time ( $t_{\rm RAH}$ ), column address set up time ( $t_{\rm ASC}$ ) and  $\overline{\rm CAS}$  output will follow  $\overline{\rm RASIN}$  as determined by the auto access modes. A maximum of one wait state is required for 6MHz and 10MHz CPUs. This wait state is automatically inserted by the  $\overline{\rm CAS}$  output of the DP8408. For systems using byte-writing, the DM74S158 provides two separate  $\overline{\rm CAS}$  outputs for ac-

cessing the low and high byte of memory. Note that  $\overline{DS}$  from the Z8000 is also gated with the DP8408's CAS output to generate  $\overline{CASL}$  and  $\overline{CASH}$ . This guarantees the valid data from the Z8000 being written into memory during memory write cycles. Refer to Figure 3 for the detailed memory transaction cycle timing.

The following formula allows the designer to determine the proper memory speed in terms of  $t_{CAC}$  (access time from  $\overline{CAS}$ ):

 $t_{CAC}$  max. =  $3 \times t_{cC} - tdc(MR) - t_{RICL} - t_{CASdly} - t_{SDR}(C) - 15$ .

The Z8000 parameters:

t<sub>cC</sub>: clock cycle time

t<sub>sDR</sub>(C): read data to clock ♥ set up time

tdc(MR): clock to MREQ delay

The DP8408, 74S158 and 74LS245 parameters:

t<sub>RICL</sub>: RASIN to CAS delay

t<sub>CASdly</sub>: the propagation delay of the 74S158

15 ns: the propagation delay of the 74LS245

(at 50 pF load)

For the 10MHz CPU and the DP8408:

 $t_{CAC}$  max. = 300 - 40 - 131 - 14 - 10 - 15 = 90 ns.

t<sub>RICL</sub> max. (mode 6) = 131 ns at 15pF load.

t<sub>CASdlv</sub> max. = 14ns at 50pF load.

Since  $\overline{\text{MREQ}}$  is connected directly to  $\overline{\text{RASIN}}$ ,  $t_{\text{RP}}$  ( $\overline{\text{RAS}}$  precharge time) and  $t_{\text{RAS}}$  ( $\overline{\text{RAS}}$  pulse width) are determined by  $\overline{\text{MREQ}}$  high and low, respectively.

#### Memory Refresh Cycle:

The Z8000 CPU contains a refresh rate counter for automatic memory refresh. This counter should be programmed during the processor initialization to determine the refresh rate. Since memory refresh is automatically inserted by the Z8000, there is no additional refresh arbitration logic allowed. The CPU's STATUS 3 (ST3) output can be directly connected to the M2 (RFSH) pin of the DP8408. During the memory refresh cycle, ST3 goes low, setting the DP8408 in the external control refresh mode (mode 2). Then all four RAS outputs will follow MREQ to strobe the DP8408's refresh address to all memory banks (the Z8000 refresh address is ignored). As MREQ goes high again, the DP8408 increments its refresh counter, preparing it for the next refresh cycle. Refer to Figure 4 for the refresh cycle timing. Note that ST3 also goes low during the internal cycle, I/O reference cycle and interrupt acknowledge cycle, but the memory will not be refreshed because MREQ is not active during these cycles. The DP8408 on-chip refresh counter will not be incremented when M2 goes low unless MREQ is inserted.

PAL is a registered trademark of Monolithic Memories, Inc. Z80 and Z80A are registered trademarks of Zilog Corp. Z8000 is a trademark of Zilog Corp.

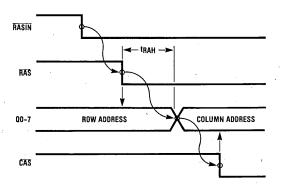


Figure 1. Auto Access Timing Sequence (Mode 5 or Mode 6)

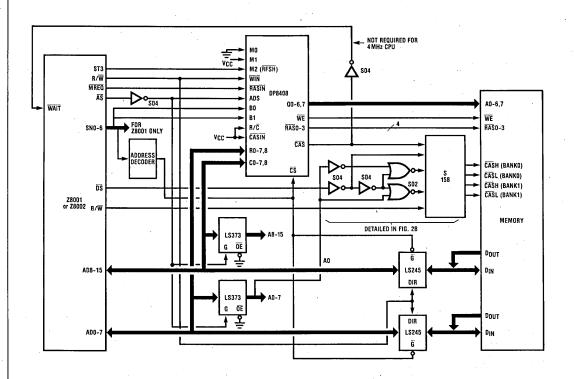


Figure 2a. Z8000 and DP8408 Interface

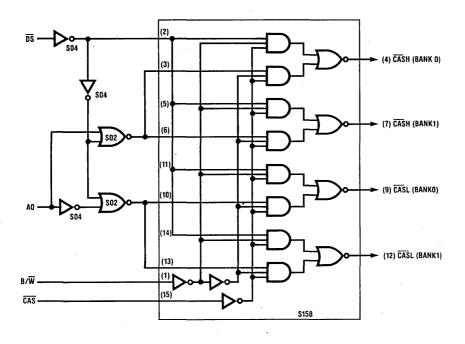


Figure 2b. CASH and CASL Decoder

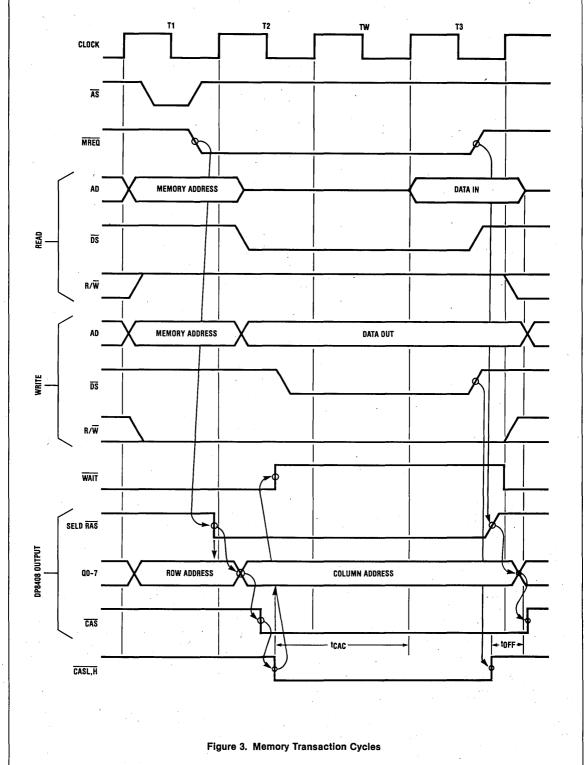
When the processor is in either halt state (by executing the privileged HALT Instruction) or single-stepping mode (when \$\overline{S}TOP\$ input is low), it introduces memory refresh cycles. However, care should be taken when the CPU is in either a WAIT state or a Bus Acknowledge cycle, that the dynamic RAM refresh will not take place. If these conditions occur over a long period of time, a burst refresh is recommended. This can be done by toggling \$\overline{R}ASIN\$ while keeping M2 low, until all the rows of the dynamic RAM have been refreshed, then the CPU can resume its operations.

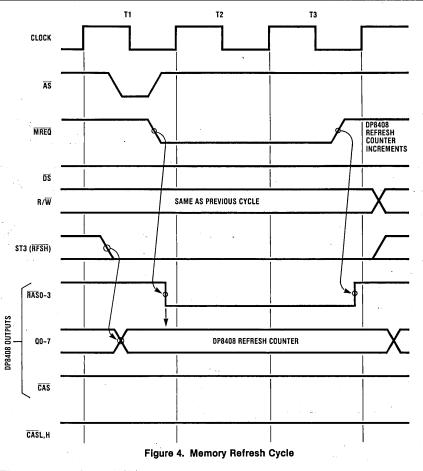
#### The DP8408 and Z80A® Interface

#### Instruction Fetch Cycle:

Figure 5 shows the detailed interconnections between the DP8408, the Z80® and the Dynamic RAMs. Figure 6 shows the timing during an M1 cycle (op code fetch). The program counter is output on the address bus at the beginning of the M1 cycle. One-half clock later, MREQ goes active. This input is used to provide RASIN to the DP8408 to access the dynamic memory. Subsequently,

the selected RAS output, Row to Column Select and then CAS output will automatically follow RASIN as determined by the Auto Access modes of the DP8408. The RD line also goes active to indicate a memory read cycle is in progress. After  $t_{CAC}$  (access time from  $\overline{CAS}$ ), read data becomes valid. This data is sampled on the rising edge of T3, then both MREQ and RD go inactive. Immediately following this, RFSH goes low, putting the DP8408 in the Externally Controlled Refresh mode. The MREQ goes active causing all four RAS outputs to go active to perform a refresh to all the banks of the dynamic RAMs. Note that during memory refresh cycles, the refresh address from the CPU is output on the address bus. However, the contents of the DP8408 on-chip refresh counter are used instead to provide the row address to the dynamic memory array. Since the Z80 provides only a 7-bit refresh address, it is an advantage to use the DP8408 8-bit refresh counter to support 64k dynamic RAMs directly. The DP8408 refresh counter is incremented as MREQ returns high, ending the memory refresh. The RFSH goes inactive returning the DP8408 back to the Auto Access mode, preparing it for the next access cycle.





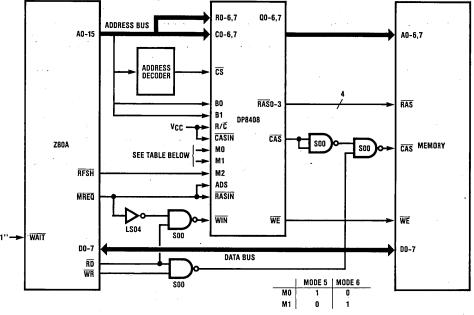


Figure 5. DP8408 and Z80A Interface

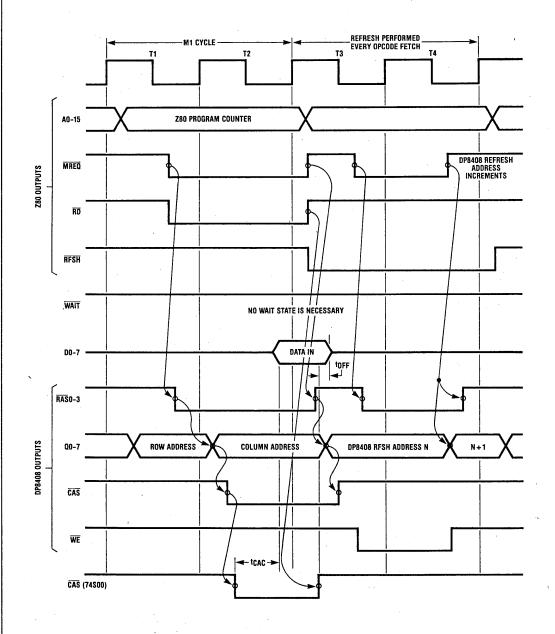


Figure 6. Z80A Op Code Fetch Cycle Showing Memory Refresh

#### Memory Access Cycle:

Figure 7 shows the timing of the memory read and memory write cycle other than for the M1 op code fetch cycle. Similar to the op code fetch cycle, MREQ is used to provide RASIN. MREQ goes active after the address to the memory has had time to stabilize. Again, RAS output, Row to Column Select and then CAS output will automatically follow RASIN to access the specified memory location. For a memory read cycle, both MREQ and RD go active, and as a result, WIN remains high (refer to Figure 5), which allows a memory read operation to occur. On the other hand, only MREQ goes active during a write cycle, which forces WIN low, indicating an early write cycle. It should be noted that the CAS output to the memory array will not go low until WR goes low during memory write cycles as this guarantees the valid CPU data will be written into memory.

It is worth mentioning that the Z80 CPU provides powerful block transfer instructions. An example is the LDIR (load, increment and repeat); using only this instruction, the programmer can move any block of data from the location pointed to by the D and E registers. This operation is repeated until the byte counter (B and C registers) reaches zero. Thus, this single instruction can move any block of data from one location to any other. Due to the fact that this instruction is refetched after each data byte transfer, the memory refresh cycle always takes place even though a transfer of up to 64k bytes of data may be performed. Furthermore, when the CPU has executed the software HALT instruction and is waiting for an interrupt before normal CPU operations can resume, the CPU executes NOP instructions to maintain memory refresh activity.

However, care should be taken when the CPU is in either WAIT state or a Bus Acknowledge cycle, the dynamic RAM refresh will not take place. If these conditions occur long enough, a burst refresh is recommended, and it can be done by toggling RASIN while keeping M2 low until all the rows of the dynamic RAM have been refreshed before the CPU can resume its operation.

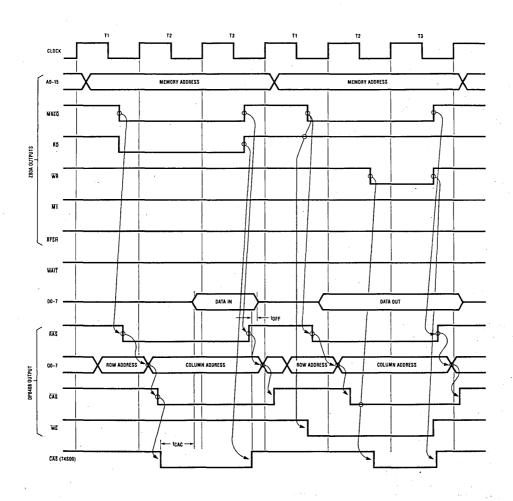


Figure 7. Z80A Memory Read and Memory Write Cycle

The following formulas allow designers to select the appropriate dynamic memory, based on different CPU and DP8408 speed versions, to allow the CPU full speed of operation:

max.  $t_{CAC}$ :  $1.5 \times t_{Cmin} - t_{DL\phi}(MR) - tRICL$ 

t<sub>CASDLY</sub> - t<sub>S4</sub>(D)

min.  $t_{RP}$ :  $tw(MRH) = tw(\phi H) + t_f - 20$ min.  $t_{RAS}$ :  $tw(MRL) - 20 = t_C - 50$ 

**Dynamic RAM Parameters:** 

 $t_{CAC}$ : access time from  $\overline{CAS}$   $t_{RP}$ :  $\overline{RAS}$  precharge time  $t_{RAS}$ :  $\overline{RAS}$  pulse width

Z80 Parameters:

t<sub>C</sub>: clock period

tw(\( \phi H )): clock pulse width, clock high

tf: clock fall time

 $t_{DL\phi}(MR)$ : MREQ delay from falling edge of clock,

MREQ low

t<sub>Sϕ</sub>(D): Data set up time to rising edge of

clock during M1 cycle

DP8408 and 74S00 Parameters:

t<sub>RICL</sub>: RASIN to CAS output delay

t<sub>CASDLY</sub>: propagation delay of the two 74S00

NAND gates

For example, if the Z80A (4MHz) and the DP8408 are

used, then:

max.  $t_{CAC}$ : 1.5(250) - 85 - 132 - 13 - 50 = 95 ns

min.  $t_{RP}$ :  $110 + 20 - 20 = 110 \,\text{ns}$ 

min.  $t_{RAS}$ :  $t_C - 50 = 200 \,\text{ns}$ 

t<sub>RICL</sub> max.

(mode 6): 132ns at 15pF load t<sub>CASDLY</sub> max.: 13ns at 50pF load

Therefore, in this case, the designer should choose a dynamic memory which has maximum  $t_{CAC}$  of 95ns, minimum  $t_{RP}$  of 110ns and minimum  $t_{RAS}$  of 200ns.

#### DP8409 and MC68B09E Interface

#### DP8409 Overview:

The DP8409 Dynamic RAM Controller/Driver is designed to control all multiplexed-address dynamic RAMs. It consists of two 9-bit address latches and a 9-bit refresh counter, thus allowing control of all 16k, 64k, and the coming generation 256k dynamic RAMs. More important, all the DP8409 outputs are capable of driving 500 pF loads.

The DP8409 basically has eight modes of operation: Externally Controlled Refresh, Automatic Forced Refresh, Internal Auto Burst Refresh, All RAS Auto Write, Externally Controlled Access, Auto Access (slow t<sub>RAH</sub> and with hidden refresh), Fast Auto Access (fast t<sub>RAH</sub>) and Set End of Count. Of all these modes, Auto Access (mode 5) and Auto Forced Refresh (mode 1) are the most popular and will be used throughout this application. Mode 5 requires only RASIN to initiate a memory access cycle, because all the dynamic RAM's

control signals are automatically delayed from this input, as shown in Figure 1. To attain maximum system throughput, it is obviously advantageous to perform refreshes without interrupting the system. The DP8409 can do this by monitoring the  $\overline{\text{CS}}$  input to see if it is high. If  $\overline{\text{CS}}$  is high, the RAMs are not being accessed. If  $\overline{\text{CS}}$  is high for one cycle, the DP8409 performs a hidden refresh during this cycle, and stops in time for the system to start another access. But if a hidden refresh does not occur in a specific time slot, a refresh must be forced and this can be done by using Mode 1, Automatic Forced Refresh.

To perform automatic forced refresh, the DP8409 must receive two clock signals: the refresh period clock, RFCK, and RGCK, the RAS-generator clock; RGCK can be the microprocessor clock. It takes approximately four RGCK clock periods to perform this automatic forced refresh. The DP8409 gives preference to hidden refresh using RFCK as a level refreence. The refresh time slot commences as RFCK goes high. If  $\overline{CS}$  goes high while RFCK is high, the refresh counter is enabled in the address outputs. All four  $\overline{RAS}$  outputs follow  $\overline{RASIN}$ ; so to perform a hidden refresh,  $\overline{RASIN}$  must be set low and the refresh counter gets incremented as  $\overline{RASIN}$  goes high. The DP8409 allows only one such lidden refresh to occur with a clock cycle of RFCK to minimize power consumption.

If a hidden refresh does not occur the DP8409 must force a refresh before RFCK begins a new cycle on a low-to-high transition. Therefore, as RFCK goes low (and a hidden refresh has not occurred), RF I/O (Refresh Request) goes low, requesting that a refresh be performed. When the system acknowledges the request, it sets M2 low, and prevents further access to the DP8409. Then two RGCK negative edges after M2 has gone low, all four RAS outputs go low and and remain low for two RGCK clock periods. After all four RAS outputs have gone low, M2 can go high any time to end the Automatic Forced Refresh. The DP8409 allows only one automatic refresh to occur within a clock cycle of RFCK.

#### **Memory Access:**

The MC68B09E starts a memory access cycle when E goes low, then the memory address becomes valid on the Address Bus A0-15. This address is decoded to provide Chip Select (CS) to the DP8409. Then Q goes high and sets RASIN low from the PAL® Control Logic as shown in Figure 12. Note that CS must go low for a minimum of 10ns before the assertion of RASIN for a proper memory access. This is important because a false hidden refresh may take place when this 10 ns minimum setup time is not met. RASIN goes low initiating the auto access sequence as shown in Figure 1. Mode 5 guarantees a 30ns minimum for row address hold time and a minimum of 8ns column address set up time. RASIN remains low until E goes low at the end of the current access cycle. Using the 16R6 A-1 Programmable Array Logic (25ns PAL), the maximum access time from CAS of the selected dynamic RAM is determined as follows:

Max.  $t_{CAC}$ :  $3 \times 125 - 25 - 160 - 40 = 150$  ns 8409  $t_{CAC}$ :  $3 \times 125 - 25 - 130 - 40 = 180$  ns 8409-2

Q high to

E low: 3 x 125 ns (8 MHz clock) = 375 ns

7

Q high to

RASIN low: 25 ns (16R6 A-1 PAL Parameter)

RASIN to CAS

Output low: 160 ns (DP8409's t<sub>RICL</sub>, Mode 5, at

500 pF load)

Read data setup 130 ns (DP8409-2's t<sub>RICL</sub>)

time (before E

going low): 40ns

#### Memory Refresh:

As described above, RASIN goes active when Q and/or E are high. This scheme, therefore, maximizes chances for hidden refresh because  $\overline{CS}$  is high during nondynamic memory cycle. For example, when the CPU is executing internal operation or the CPU is accessing ROM or I/O,  $\overline{CS}$  is high during these times. The DP8409 therefore performs a hidden refresh as  $\overline{RASIN}$  goes low, assuming that RFCK is high.

However, if no hidden refresh occurs while RFCK was high, RF I/O goes low immediately after the RFCK high-tolow transition requests a forced refresh. The PAL Control Logic samples RF I/O, when E and Q are high and low respectively, to set M2 (RFSH) low, as shown in Figure 13. Once M2 has gone low, a forced refresh automatically occurs (as described in the DP8409 Overview). M2 remains low for four system clock periods to allow for this forced refresh. If the current microprocessor cycle is a nondynamic memory cycle (CS is high), this refresh is transparent to the microprocessor and STRETCH remains high (E and Q are not stretched). Nevertheless, if the current cycle is a dynamic memory access cycle, STRETCH goes low stretching E and Q for a maximum of four system clocks. RASIN for the pending access will be issued a full system clock after M2 has gone high; this is to allow some RAS precharge time for the dynamic RAM. After this, memory will be accessed in the manner as described in the Memory Access Cycle.

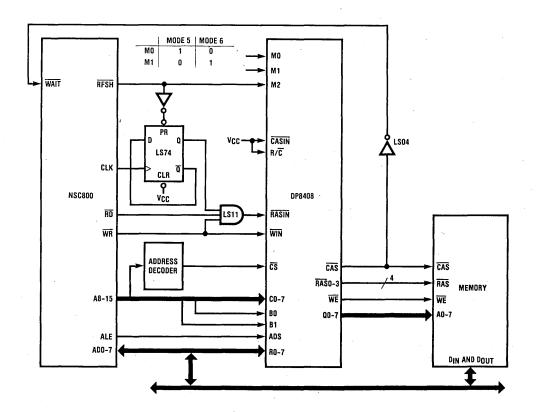


Figure 8. NSC800 and DP8408 Interface

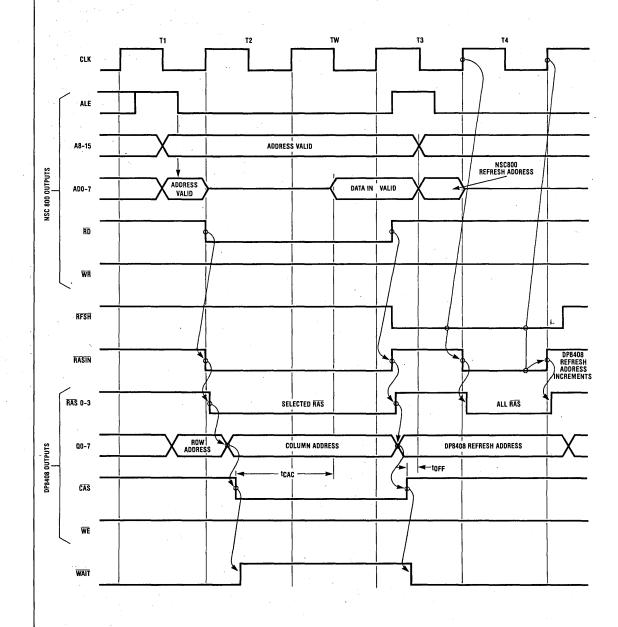


Figure 9. NSC800 Op Code Fetch Cycle Showing Memory Refresh

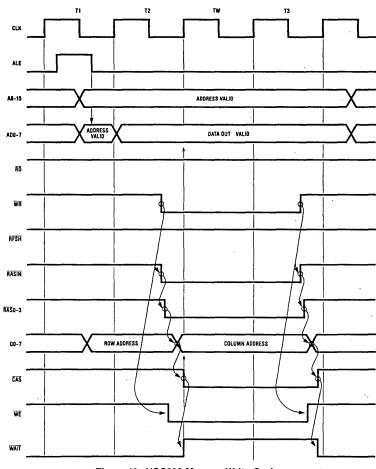


Figure 10. NSC800 Memory Write Cycle

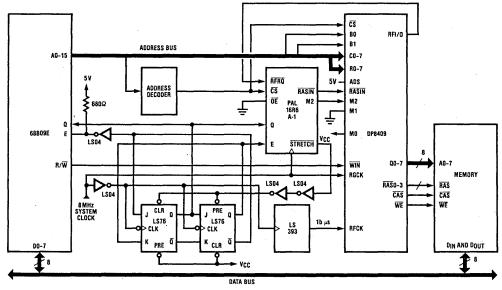
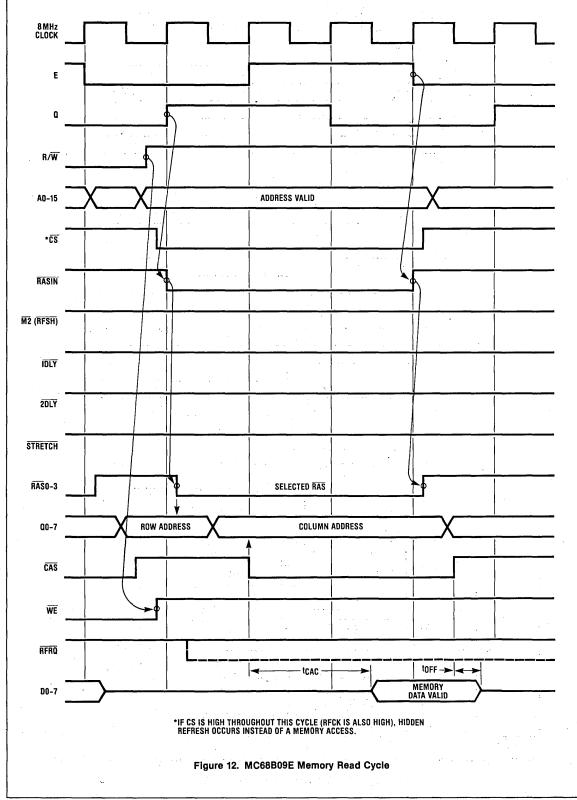
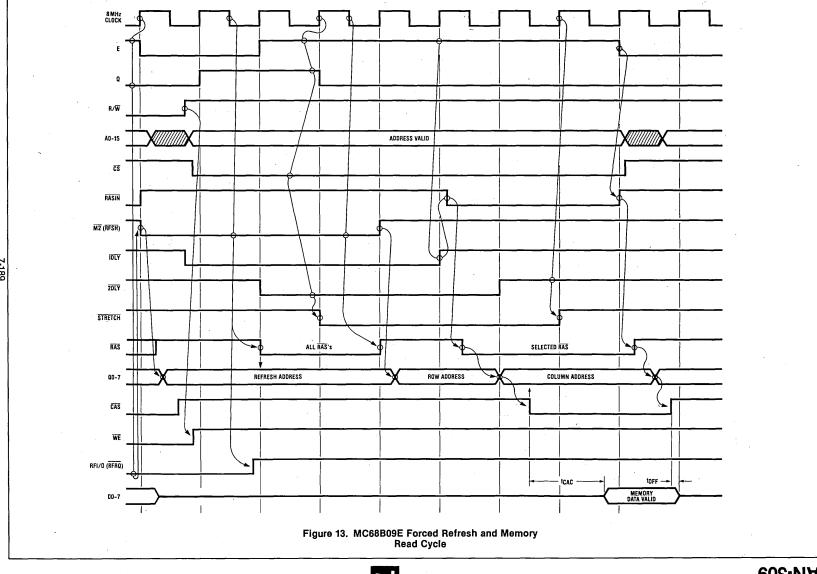


Figure 11. MC68B09E and DP8409 Interface





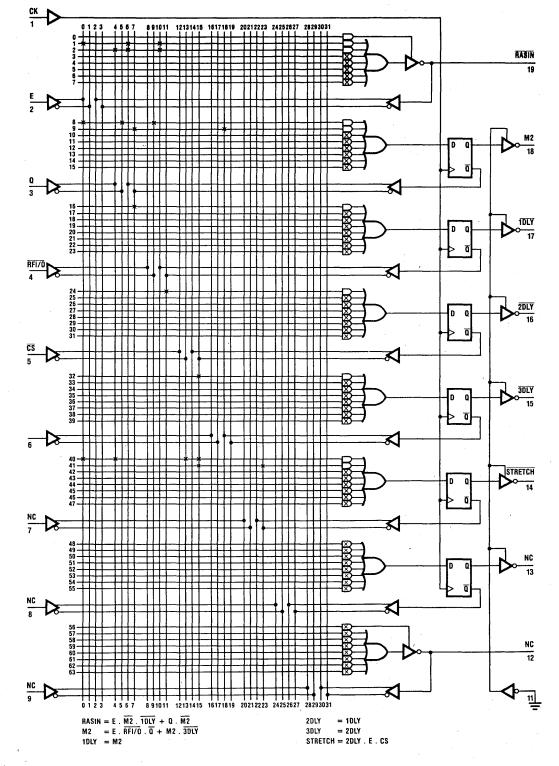


Figure 14. PAL (16R6 A-1) Control Logic

## Memory Systems with ECC Using the DP8400

National Semiconductor Application Brief #2 Brian Edem June 1982



This brief explains how a memory system can easily perform single error correction, double error detection, auto accessing and refreshing of memory, and byte writing.

Figure 1 shows the NS16032 with DP8409, DP8400, and a 2-PAL® (Programmable Array Logic) controller. The memory cycle for the NS16032 starts at the CPU clock cycle where the address strobe goes active. At the middle of this clock cycle, the 74ALS02 latch is set, providing RASIN to the DP8409 Dynamic RAM Controller, which starts its Auto Access cycle. The latch output is also sent to the two PAL controllers, indicating that a memory cycle has started. On the next PAL clock cycle (50 ns later), the PAL will enter one of five memory cycles: Read, Byte-Write, Word-Write, or Cycle Inhibit.

For a read cycle, one wait state will be needed, so the controller pulls the NCWAIT line low for one CPU clock cycle. Three CPU clock cycles after RASIN, the corrected data is latched at the output of the DP8400, the memory buffers are disabled, and the DP8400's output buffers are enabled. At the beginning of the fifth CPU clock cycle, the CPU latches the data from the data bus, and the PAL deactivates all control signals, resets the 74ALS02 latch, and outputs an interrupt to the CPU if a double error is detected. This allows the CPU to gracefully crash or perform a memory test on the system.

In a byte-write cycle, the data must first be read from memory to be corrected if necessary. The new byte to be written, along with the byte that remains unchanged, will then be written to memory with the new checkbits.

The byte-write memory cycle needs two wait states, so the PAL controller first pulls the NCWAIT line low for two CPU clock cycles. Three CPU clock cycles after RASIN is activated, corrected data is latched at the output of the DP8400. Also at this time the memory buffers are disabled, the new byte from the CPU and the unaddressed memory byte from the DP8400 are enabled onto the internal data bus, creating a new word of data. A half of the CPU clock cycle after the new data is enabled, it is latched into the DP8400, the mode of which has been changed to generate check bits. A half of the CPU clock cycle after the data has been latched into the input of the DP8400, the data is again latched at the output to the DP8400 along with the newly generated check bits. Also at this time, a write strobe is generated by the PAL. At the end of the write strobe, the PAL outputs a reset pulse, resetting the 74ALS02 latch. If a double bit error occurred during the read portion of the memory cycle, then the interrupt will be triggered.

For a word-write cycle, no wait states are used. The buffer from the CPU is enabled, the DP8400 is put into a write mode, and the DP8409 is instructed to write memory. After CAS has occurred, the PAL controller resets the 74ALS02 latch.

During any memory cycle that the dynamic RAM is not selected, the controller effectively performs a cycle inhibit, allowing the DP8409 to perform a refresh if needed. One CPU clock cycle after the cycle starts, the 74ALS02 latch is cleared. The DP8409 will use this short RASIN strobe to generate an All-RAS strobe if a hidden refresh is pending.

If a hidden refresh has not occurred in the allocated time (period of RFCK high), a forced refresh will be requested. The PAL controller will wait for the end of the current memory cycle, and immediately request a cycle hold, and then switch the DP8409 to the auto refresh mode. While the NS16201 is in the cycle hold state, NTSO will stay high, preventing the start of another memory cycle. After sufficient time has been allowed for the DP8409 to perform a forced refresh, the PAL controller will remove the cycle hold.

Figure 2 shows how, using the 68000, DP8409 and DP8400, and a controller, the same functions can be performed with a memory system controlled by a 68000 microprocessor. Timing for the 68000 system is similar to that for the NS16000, except for forced refresh and the generation of RASIN. The 68000 does not have a feature equivalent to cycle hold, so DTACK (Data Acknowledge) must be delayed if a memory cycle is requested during a forced refresh.

PAL is a registered trademark of Monolithic Memories, Inc.

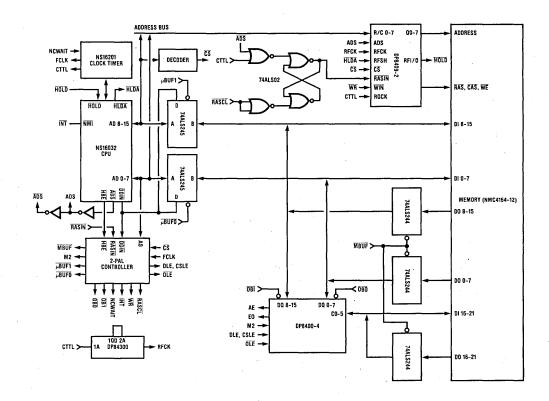


Figure 1. Memory System for NS16032 Using DP8409, DP8400, and 64k Dynamic RAMs, Performing Error Checking/Correcting, Refreshing and Byte-Writing

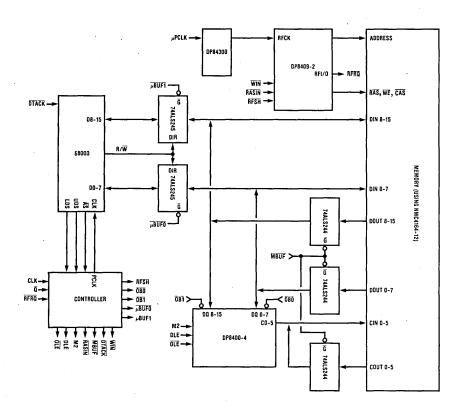
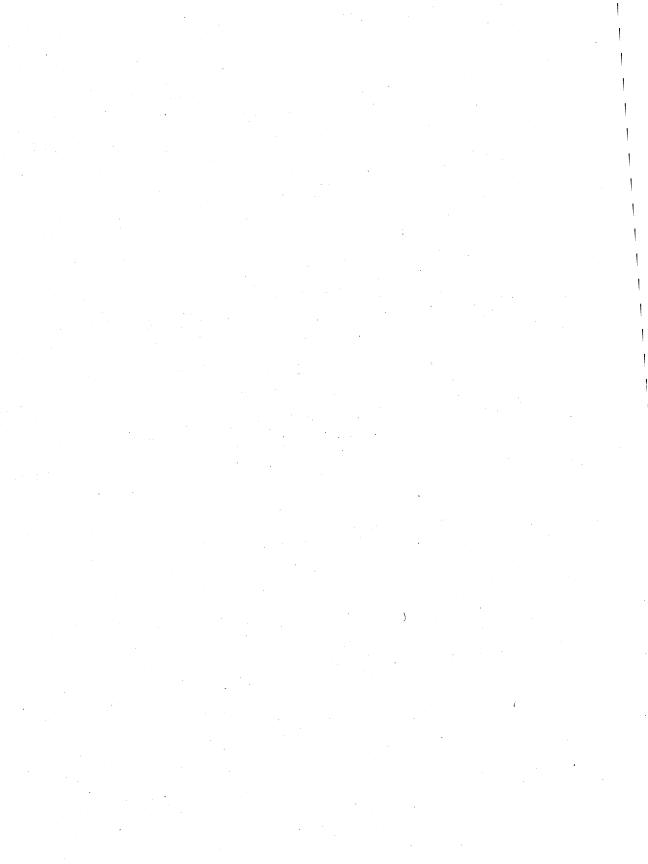


Figure 2. Memory System for the 68000 Using DP8409, DP8400 and 64k Dynamic RAMs





## Section 8 Microprocessor Support



TEMPERATU	RE RANGE	DESCRIPTION	PAGE
- 55°C to + 125°C	0°C to +70°		NUMBER
DP8212M	DP8212	8-Bit Input/Output Port	8-4
*DP8216M	DP8216	4-Bit Bidirectional Bus Transceiver	8-11
*DP8226M	DP8226	4-Bit Bidirectional Bus Transceiver	8-11
_	DP8224	Clock Generator and Driver	8-16
*DP8228M	DP8228	System Controller and Bus Driver	8-22
*DP8238M	DP8238	System Controller and Bus Driver	8-22
_	NS16201	NS16000 Timing Control Unit	Microprocessor

<sup>\*</sup>Also available screened in accordance with MIL-STD-883 Class B. Refer to National Semiconductor's "The Reliability Handbook".

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#### MICROPROCESSOR SUPPORT CIRCUITS

DESCRIPTION	GENERAL	8080	PART	NUMBER	PAGE	
DESCRIPTION	PURPOSE	CPU	0°C to +70°C	-55°C to +125°C	NO.	
8-Bit I/O Port	•	• • :	DP8212	DP8212M	8-4	
4-Bit Parallel Receiver/Driver	•	•	DP8216,	DP8216M,	8-11	
			DP8226	DP8226M	8-11	
Clock Generator/Driver		•	DP8224		8-16	
System Controller/Bus Driver		•	DP8228,	DP8228M,	8-22	
			DP8238	DP8238M	8-22	
8-Bit 48 mA Bus Transceiver	•		DP8303	DP7303	2-6	
8-Bit 48 mA Bus Transceiver	•		DP8304B	DP7304B	2-11	
8-Bit 48 mA Bus Transceiver	•		DP8307	DP7307	2-16	
8-Bit 48 mA Bus Transceiver	•		DP8308	DP7308	2-20	
CRT Controller	•	•	DP8350	A. A. A. A. A. A. A. A. A. A. A. A. A. A	5-6	
CRT Controller	•	•	DP8352,		5-6	
CRT Controller	•	•	DP8353	,	5-6	
Octal D-Type Latch	•		MM74C373	MM54C373	CMOS	
Octal D-Type Flip-Flop	•		MM74C374	MM54C374	CMOS	
16-Key Encoder	•		MM74C922	MM54C922	CMOS	
20-Key Encoder	•		MM54C923	MM54C923	CMOS	
Octal Transparent D Latch	•		DM74LS373	DM54LS373	LOGIC	
Octal Edge-Triggered D Flip-Flop	•		DM74LS374	DM54LS374	LOGIC	



#### **Microprocessor Support**

#### DP8212/DP8212M 8-Bit Input/Output Port

#### **General Description**

The DP8212/DP8212M is an 8-bit input/output port contained in a standard 24-pin dual-in-line package. The device, which is fabricated using Schottky Bipolar technology, is part of National Semiconductor's N8080A microcomputer family. The DP8212/DP8212M can be used to implement latches, gated buffers, or multiplexers. Thus, all of the major peripheral and input/output functions of a microcomputer system can be implemented with this device.

The DP8212/DP8212M includes an 8-bit latch with TRI-STATE® output buffers, and device selection and control logic. Also included is a service request flip-flop for the generation and control of interrupts to the microprocessor.

#### **Features**

- · 8-Bit Data Latch and Buffer
- Service Request Flip-flop for Generation and Control of Interrupts
- 0.25mA Input Load Current
- TRI-STATE TTL Output Drive Capability
- Outputs Sink 15mA
- Asynchronous Latch Clear
- 3.65V Output for Direct Interface to INS8080A
- Reduces System Package Count by Replacing Buffers, Latches, and Multiplexers in Microcomputer Systems

#### N8080A Microcomputer Family Block Diagram ROM: RAMs φ1 & φ2 CLOCKS CONTROL SIGNALS (RESET & READY) SYSTEM RESET DP8224 CLOCK GENERATOR INTERRUPT, INS8080A MICROPROCESSOR Μл DRÎVER DS1 WAIT CONTROL LOGIC DS2 HOLD (SYSTEM DMA REQ.) 07-00 A15-A0 OUTPUT DEVICE OPTIONAL BUFFERS/ DECODERS DP8228/ STSTB DP8238 SYSTEM OUTPUT BUFFERS CONTROLLE ADDRESS BUS (16) BUSEN BUS (8) DP8212/DP8212M CONTROL (5) PARALLEL I/O INTERFACE SERIAL INTERFACE

#### **Absolute Maximum Ratings**

#### **Operating Conditions**

			MIIN	MAX	UNITS
Storage Temperature	-65°C to +160°C	Supply Voltage (VCC)			
All Output or Supply Voltages	-0.5V to +7V	DP8212M	4.50	5.50	VDC
All Input Voltages	-1.0V to 5.5V	DP8212	4.75	5.25	VDC
Output Currents	125 mA	Operating Temperature (T <sub>A</sub> )			
Maximum Power Dissipation* at 25°C		DP8212M	-55	+125	°C
Cavity Package	1903 mW	DP8212	0	+75	°C
Maldad Dealtons	200E M		-		-

<sup>\*</sup>Derate cavity package 12.7 mW/° C above 25° C; derate molded package 16.0 mW/° C above 25° C.

Note: Maximum ratings indicate limits beyond which permanent damage may occur. Continuous operation at these limits is not intended and should be limited to those conditions specified under dc electrical characteristics.

#### **Electrical Characteristics** (Min $\leq$ TA $\leq$ Max, Min $\leq$ VCC $\leq$ Max, unless otherwise noted)

SYMBOL	PARAMETER	CONDITI	ONS	MIN	TYP	MAX	UNITS
ΙĖ	Input Load Current, STB, DS2, CLR, DI <sub>1</sub> -DI <sub>8</sub> Inputs	VF = 0.45V				-0.25	mA
ΙF	Input Load Current, MD Input	VF = 0.45V				-0.75	mA
lF	Input Load Current, DS1 Input	VF = 0.45V				-1.0	mA
IR	Input Leakage Current STB, DS2, CLR, DI1-DI8 Inputs	V <sub>R</sub> = V <sub>CC</sub> Max				10	μА
IR	Input Leakage Current, MD Input	VR = VCC Max				30	μΑ
I <sub>R</sub>	Input Leakage Current, DS1 Input	VR = VCC Max				40	μΑ
٧c	Input Forward Voltage Clamp	IC = -5 mA				-1	V
VIL	Input "Low" Voltage		DP8212M			0.80	V
			DP8212			0.85	V
VIH	Input "High" Voltage			2.0			V
VOL	Output "Low" Voltage	IOL = 10 mA	DP8212M			0.45	V
	· I	I <sub>OL</sub> = 15 mA	DP8212		-	0.45	٧
Voн	Output "High" Voltage	I <sub>OH</sub> = -0.5 mA	DP8212M	3.40	4.0		
	· ·	IOH = -1.0 mA	DP8212	3.65	4.0		V
Isc	Short-Circuit Output Current	VO = 0V, VCC = 5	SV .	-15	-	<b>−75</b>	mA
liol	Output Leakage Current, High Impedance State	V <sub>O</sub> = 0.45V/V <sub>CC</sub>	Max			20	μΑ
Icc	Power Supply Current		DP8212M		90	145	mA
	1		DP8212		90	130	mΑ

#### Capacitance \*

F = 1MHz,  $V_{BIAS} = 2.5V$ ,  $V_{CC} = 5V$ ,  $T_A = 25^{\circ}C$ .

SYMBOL	PARAMETER	MIN	TYP	MAX	UNITS
CIN	DS1, MD Input Capacitance		. 9	12	pF
CIN	DS2, CLR, STB, DI <sub>1</sub> -DI <sub>8</sub> Input Capacitance		5	9	pF
COUT	DO1-DO8 Output Capacitance		8	12	pF

<sup>\*</sup>This parameter is sampled and not 100% tested.

#### **Switching Characteristics**

 $(Min \le T_{\mathsf{A}} \le Max, Min \le V_{\mathsf{CC}} \le Max)$ 

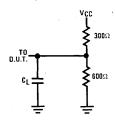
01/14001	PARAMETER	CONDITIONS	DP8212M_		DP8212		UNITS	
SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	MIN	MAX	OMITS	
tpW	Pulse Width		40		30		ns	
tPD	Data to Output Delay	(Note 5)		30		30	ns	
tWE	Write Enable to Output Delay	(Note 5)		50		40	ns	
tSET	Data Set-Up Time		20		15		ns	
tH	Data Hold Time		30		20		ns	
tR	Reset to Output Delay	(Note 5)		55		40	ns	
ts	Set to Output Delay	(Note 5)		35	,	30	ns	
tE	Output Enable/Disable Time	(Note 6)		50		45	ns	
tC	Clear to Output Delay	(Note 5)		65 .		55	ns	

#### **Switching Conditions**

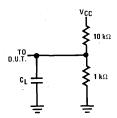
#### Conditions of Test:

- 1. Input Pulse Amplitude = 2.5 V.
- 2. Input Rise and Fall Times = 5ns.
- 3. Between 1V and 2V Measurements made at 1.5V with 15mA & 30pF Test Load.
- 4. CL includes jig and probe capacitance.
- 5. CL = 30 pF.
- 6.  $C_L = 30 pF$  except for DP8212M tE(DISABLE)  $C_L = 5 pF$

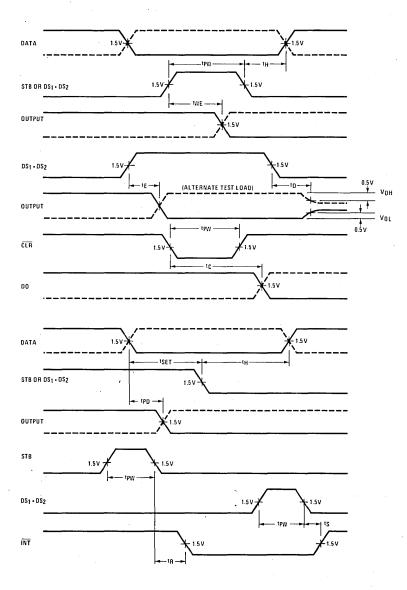
Test Load



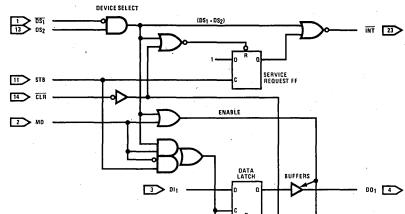
#### Alternate Test Load (Refer to Timing Diagram)



#### Timing Diagram



#### **Logic Diagram**



Logic Table A

STB	MD	(DS <sub>1</sub> ·DS <sub>2</sub> )	DATA OUT _EQUALS_
0	0	0	TRI-STATE
1	0	0	TRI-STATE
0	1	0 .	DATA LATCH
1	1	0	DATA LATCH
0	0	1	DATA LATCH
1	0	1	DATA IN
0	1	1	DATA IN
1	1	. 1	DATA IN

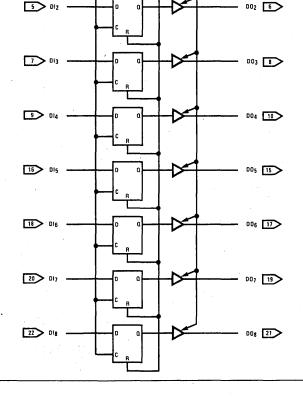
CLR \resets data latch to the output low state.

The data latch clock is level sensitive, a low level clock latches the data.

Logic Table B

CLR	(DS <sub>1</sub> ·DS <sub>2</sub> )	STB	o,	INT
O RESET	. 0	. 0	0	1
1	0	0 .	0	1
1	0		1	0
1	1 RESET	0	0	0
11	0	0	0	- 1

<sup>\*</sup>Internal Service Request flip-flop.



#### **Functional Pin Definitions**

The following describes the function of all the DP8212/DP8212M input/output pins. Some of these descriptions reference internal circuits.

#### **INPUT SIGNALS**

**Device Select (\overline{DS\_1}, DS\_2):** When  $\overline{DS_1}$  is low and  $DS_2$  is high, the device is selected. The output buffers are enabled

and the service request flip-flop is asynchronously reset (cleared) when the device is selected.

Mode (MD): When high (output mode), the output buffers are enabled and the source of the data latch clock input is the device selection logic (DS $_1$ ·DS $_2$ ). When low (input mode), the state of the output buffers is determined by the device selection logic (DS $_1$ ·DS $_2$ ) and the source of the data latch clock input is the strobe (STB) input.

#### Functional Pin Definitions (Continued)

Strobe (STB): Used as data latch clock input when the mode (MD) input is low (input mode). Also used to synchronously set the service request flip-flop, which is negative edge triggered.

Data In (DI<sub>1</sub> - DI<sub>8</sub>): Eight-bit data input to the data latch, which consists of eight D-type flip-flops. Incorporating a level sensitive clock while the data latch clock input is high, the Q output of each flip-flop follows the data input. When the clock input returns low, the data latch stores the data input. The clock input high overrides the clear (CLR) input data latch reset.

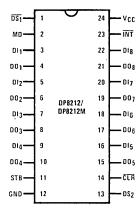
Clear (CLR): When low, asynchronously resets (clears) the data latch and the service request flip-flop. The service request flip-flop is in the non-interrupting state when reset.

#### **OUTPUT SIGNALS**

Interrupt (INT): Goes low (interrupting state) when either the service request flip-flop is synchronously set by the strobe (STB) input or the device is selected.

Data Out (DO<sub>1</sub> - DO<sub>8</sub>): Eight-bit data output of data buffers, which are TRI-STATE, non-inverting stages. These buffers have a common control line that either enables the buffers to transmit the data from the data latch outputs or disables the buffers by placing them in the high-impedance state.

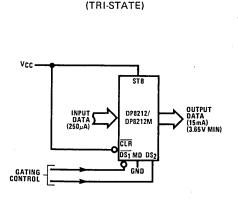
#### **Connection Diagram**

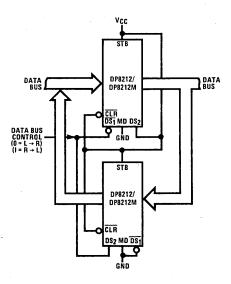


Order Number DP8212J, DP8212N or DP8212MJ See NS Package J24A or N24A

#### **Applications in Microcomputer Systems**

**Gated Buffer** 



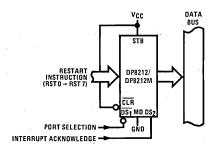


#### **Applications in Microcomputer Systems (Continued)**

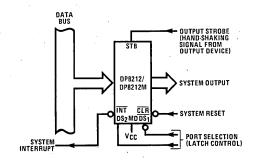
#### **Interrupting Input Port**

# INPUT STROBE (FROM INPUT DEVICE) SYSTEM OP8212/ DP821

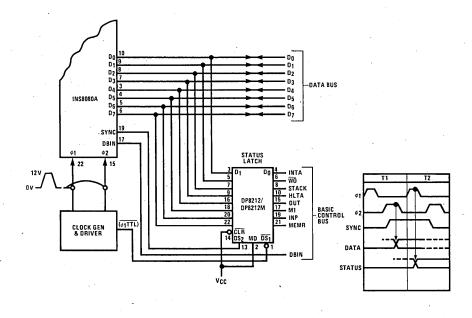
#### **Interrupt Instruction Port**



#### Output Port (with Hand-Shaking)



#### INS8080A Status Latch





#### **Microprocessor Support**

#### DP8216/DP8216M, DP8226/DP8226M 4-Bit Bidirectional Bus Transceivers

#### **General Description**

The DP8216/DP8216M and DP8226/DP8226M are 4-bit bidirectional bus drivers for use in bus oriented applications. The non-inverting DP8216/DP8216M and inverting DP8226/DP8226M drivers are provided for flexibility in system design.

Each buffered line of the four-bit driver consists of two separate buffers that are TRI-STATE® to achieve direct bus interface and bidirectional capability. On one side of the driver the output of one buffer and the input of another are tied together (DB); this side is used to interface to the system side components such as memories, I/O, etc., because its interface is TTL compatible and it has high drive (50 mA). On the other side of the driver the inputs and outputs are separated to provide maximum flexibility. Of course, they can be tied together so that the driver can be used to buffer a true bidirectional bus. The DO outputs on this side of the driver have a special high voltage output drive capability so that direct interface to the 8080 type CPUs is achieved with an adequate amount of noise immunity.

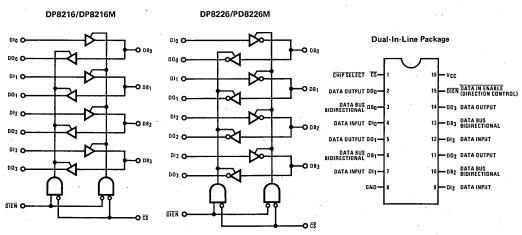
The CS input is a device enable. When it is "high" the output drivers are all forced to their high-impedance state. When it is a "low" the device is enabled and the direction of the data flow is determined by the DIEN input.

The DIEN input controls the direction of data flow, which is accomplished by forcing one of the pair of buffers into its high-impedance state and allowing the other to transmit its data. A simple two-gate circuit is used for this function.

#### **Features**

- Data bus buffer driver for 8080 type CPUs
- Low input load current 0.25 mA maximum
- High output drive capability for driving system data bus — 50 mA at 0.5 V
- Power up-down protection
- DP8216/DP8216M have non-inverting outputs
- DP8226/DP8226M have inverting outputs
- Output high voltage compatible with direct interface to MOS
- TRI-STATE outputs
- Advanced Schottky processing
- Available in military and commercial temperature ranges

#### **Logic and Connection Diagrams**



Order Number DP8216J, DP8216N, DP8226J, DP8226N, DP8216MJ or DP8226MJ See NS Package J16A or N16A

<b>Absolute Maximum Ratings</b>	6 (Note 1)	<b>)</b>		<b>Operating Condit</b>	ions	٠,	
	Min	Max	Units		Min	Max	Units
All Output and Supply Voltages	-0.5	+7.0	V	Supply Voltage, VCC			
All Input Voltages	-1.0	+5.5	V	DP8216M, DP8226M	4.5	5.5	V
Output Currents		125	mΑ	DP8216, DP8226	4.75	5.25	V
Storage Temperature	-65	+150	°c	Temperature, TA	-	.405	° 0
Maximum Power Dissipation* at 25°C				DP8216M, DP8226M DP8216, DP8226	-55 0	+125 +70	°C °C
Cavity Package		1509	mW	,			
Molded Package		1476	mW				
Lead Temperature (soldering, 10 seconds)		+300	°C				

Derate cavity package 10.1 mW/°C above 25°C; derate molded package 11.8 mW/°C above 25°C.

## Electrical Characteristics DP8216, DP8226 $V_{CC}$ = 5 V $\pm$ 5% (Notes 2, 3, and 4)

VIH IIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIII	Input Low Voltage Input High Voltage Input Load Current	Conditions	Min	Тур	Max	Units
VIL III VIH III IF III	Input Low Voltage Input High Voltage Input Load Current				•	
VIH IIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIII	Input High Voltage					
IF I	Input Load Current				0.95	V
IR I	•		2			V
		V <sub>F</sub> = 0.45 V		-0.03	-0.25	mA
., .	Input Leakage Current	V <sub>R</sub> = 5.25 V			10	μΑ
VC I	Input Clamp Voltage	I <sub>C</sub> = -5 mA			-1.2	V
VOL1	Output Low Voltage	IOL = 25 mA		0.3	0.45	, v
VOL2	Output Low Voltage	DP8216 IOL = 55 mA		0.5	0.6	. v
VOLZ	Output Low Voltage	DP8226 IOL = 50 mA	·	0.5	0.0	· •
VOH C	Output High Voltage	I <sub>OH</sub> = -10 mA	2.4	3.0		V
ISC C	Output Short Circuit Current	V <sub>CC</sub> = 5.0 V	-30	-75	-120	mA
liol c	Output Leakage Current TRI-STATE	V <sub>O</sub> = 0.45 V/5.5 V			100	μΑ
RECEIVE	ERS					
VIL I	Input Low Voltage	·			0.95	V
ViH I	Input High Voltage		2			V
le li	Input Load Current	VF = 0.45 V		-0.08	-0.25	mÀ
VC I	Input Clamp Voltage	IC = -5 mA			-1.2	V
VOL C	Output Low Voltage	IOL = 15 mA		0.3	0.45	V
VOH1 C	Output High Voltage	IOH = -1 mA	3.65	4.0		V
ISC C	Output Short Circuit Current	V <sub>O</sub> ≈ 0 V	-15	-35	-65	mA
liol c	Output Leakage Current TRI-STATE	V <sub>O</sub> = 0.45 V/5.5 V			20	μΑ
CONTRO	L INPUTS (CS, DIEN)					
VIL I	Input Low Voltage				0.95	V
VIH I	Input High Voltage		2			V
ie li	Input Load Current	V <sub>F</sub> = 0.45 V		-0.15	-0.5	mA
IR I	Input Leakage Current	V <sub>R</sub> = 5.25 V			20	μА
ICC P	Power Supply Current DP8216 DP8226			95 85	130 120	- mA mA

Parameter				Limits		
Symbol	Description	Conditions	Min	Тур	Max	Units
DRIVE	RS					
VIL	Input Low Voltage DP8216M DP8226M				0.95 0.90	\ V
VIH	Input High Voltage		2			V
۱۴	Input Load Current	V <sub>F</sub> = 0.45 V		-0.08	-0.25	mA
IR	Input Leakage Current	V <sub>R</sub> = 5.5 V			40	μΑ
٧c	Input Clamp Voltage	IC = -5 mA			-1.2	٧
VOL1	Output Low Voltage	IOL = 25 mA		0.3	0.45	V
V <sub>OL2</sub>	Output Low Voltage	IOL = 45 mA		0.5	0.6	٧
Voн	Output High Voltage	IOH = -5 mA	2.4	3.0		V
Isc	Output Short Circuit Current	V <sub>CC</sub> = 5.0 V	-30	-75	-120	mA
IO	Output Leakage Current TRI-STATE	V <sub>O</sub> = 0.45 V/5.5 V			100	μΑ
RECEIV	VERS					
VIL	Input Low Voltage DP8216M DP8226M				0.95 0.9	V
VIH	Input High Voltage		2			V
ΙF	Input Load Current	V <sub>F</sub> = 0.45 V		-0.08	-0.25	mA
٧c	Input Clamp Voltage	IC = -5 mA			-1.2	V
VOL	Output Low Voltage	IOL = 15 mA		0.3	0.45	V
VoH1	Output High Voltage	I <sub>OH</sub> = -0.5 mA	3.4	3.8		V
V <sub>OH2</sub>	Output High Voltage	IOH = -2 mA	2.4			V
I <sub>SC</sub>	Output Short Circuit Current	V <sub>CC</sub> = 5.0 V	-15	-35	-65	mA
IOI	Output Leakage Current TRI-STATE	V <sub>O</sub> = 0.45 V/5.5 V			20	μΑ
CONTR	OL INPUTS (CS, DIEN)					:
VIL	Input Low Voltage DP8216M DP8226M				0.95 0.9	· v
VIH	Input High Voltage		2			V
lF .	Input Load Current	VF = 0.45 V		-0.15	-0.5	mA
IR	Input Leakage Current	V <sub>R</sub> = 5.5 V			80	μΑ
ICC	Power Supply Current DP8216M			95	130	mA

#### Switching Characteristics (Notes 2, 3, and 4)

	Parameter			Limits		
Symbol	Description	Conditions	Min	Тур	Max	Units
DP8216	6M, DP8226M, V <sub>CC</sub> = 5V ±10%		,			
tPD 1	Input to Output Delay, DO Outputs	$C_L = 30 \text{ pF}, R_1 = 300 \Omega,$ $R_2 = 600 \Omega$	. ,	15	25	'ns
tPD2	Input to Output Delay, DB Outputs DP8216M DP8226M	$C_L = 300  pF, R_1 = 90  \Omega,$ $R_2 = 180  \Omega$		19 16	33 25	ns ns
tE	Output Enable Time DP8216M DP8226M	DO Outputs: $C_L = 30  \text{pF}$ , $R_1 = 300  \Omega/10  \text{k}\Omega$ , $R_2 = 600  \Omega/1  \text{k}\Omega$ DB Outputs: $C_L = 300  \text{pF}$ , $R_1 = 90  \Omega/10  \text{k}\Omega$ , $R_2 = 180  \Omega/1  \text{k}\Omega$		42 36	75 62	ns ns
tD	Output Disable Time DP8216M DP8226M	DO Outputs: $C_L = 5  pF$ , $R_1 = 300  \Omega/10  k\Omega$ , $R_2 = 600  \Omega/1  k\Omega$ DB Outputs: $C_L = 5  pF$ , $R_1 = 90  \Omega/10  k\Omega$ , $R_2 = 180  \Omega/1  k\Omega$		16 16	40 38	ns ns
DP8216	6, DP8226 V <sub>CC</sub> = 5.0 V ± 5%				L	
<sup>t</sup> PD 1	Input to Output Delay, DO Outputs	$C_L = 30  pF, R_1 = 300  \Omega,$ $R_2 = 600  \Omega$		15	25	ns
tPD2	Input to Output Delay, DB Outputs DP8216 DP8226	$C_L = 300 \text{ pF}, R_1 = 90 \Omega,$ $R_2 = 180 \Omega$		20 16	30 25	ns
tΕ	Output Enable Time DP8216 DP8226	DO Outputs: $C_L = 30  pF$ , $R_1 = 300  \Omega/10  k\Omega$ , $R_2 = 600  \Omega/1  k\Omega$ DB Outputs: $C_L = 300  pF$ , $R_1 = 90  \Omega/10  k\Omega$ , $R_2 = 180  \Omega/1  k\Omega$		45 35	65 54	ns ns
tD	Output Disable Time	DO Outputs: $C_L = 5  pF$ , $R_1 = 300  \Omega/10  k\Omega$ , $R_2 = 600  \Omega/1  k\Omega$ DB Outputs: $C_L = 5  pF$ , $R_1 = 90  \Omega/10  k\Omega$ , $R_2 = 180  \Omega/1  k\Omega$		20	35	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the  $-55^{\circ}$  C to  $+125^{\circ}$  C temperature range for the DP8216M and DP8226M and across the  $0^{\circ}$  C to  $+70^{\circ}$  C temperature range for the DP8216 and DP8226. All typical values are given for  $V_{CC} = 5 V$  and  $T_A = 25^{\circ}$  C.

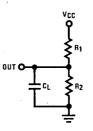
Note 3: All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to ground unless otherwise specified.

Note 4: Only one output at a time should be shorted.

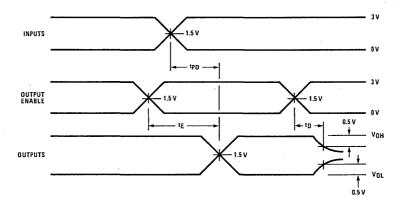
#### **Test Conditions**

#### **Test Load Circuit**

Input pulse amplitude of  $2.5\,\text{V}$ . Input rise and fall times of  $5.0\,\text{ns}$  between  $1.0\,\text{V}$  and  $2.0\,\text{V}$ . Output loading is  $5.0\,\text{mA}$  and  $10\,\text{pF}$ . Speed measurements are made at  $1.5\,\text{V}$  levels.



#### **Switching Time Waveforms**



#### Capacitance TA = 25°C

			Limit		
Symbol	Parameter	Min.	Тур.	Max.	Unit
CIN	Input Capacitance		· 4	6	рF
COUT	Output Capacitance DO Outputs DB Outputs		6 13	10 18	pF pF

Note: This parameter is periodically sampled and is not 100% tested. Condition of measurement is f = 1 MHz,  $V_{B1AS}$  = 2.5 V,  $V_{CC}$  = 5.0 V, and  $T_A$  = 25° C.



#### **Microprocessor Support**

#### **DP8224 Clock Generator and Driver**

#### **General Description**

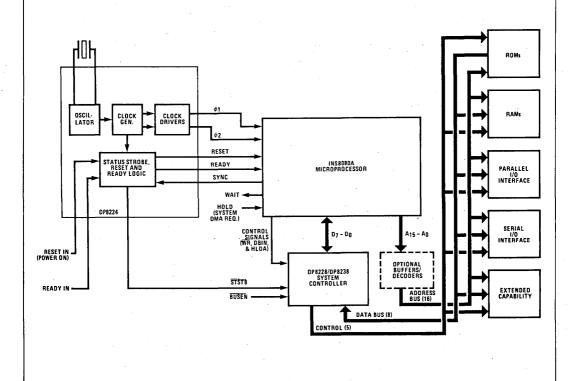
The DP8224 is a clock generator/driver contained in a standard, 16-pin dual-in-line package. The chip, which is fabricated using Schottky Bipolar technology, generates clocks and timing for National Semiconductor's N8080A microcomputer family.

Included in the DP8224 is an oscillator circuit that is controlled by an external crystal, which is selected by the designer to meet a variety of system speed requirements. Also included in the chip are circuits that provide: a status strobe for the DP8228 or DP8238 system controllers, power-on reset for the INS8080A microprocessor, and synchronization of the READY input to the INS8080A.

#### **Features**

- Crystal-Controlled Oscillator for Stable System Operation
- Single Chip Clock Generator and Driver for INS8080A Microprocessor
- Provides Status Strobe for DP8228 or DP8238 System Controllers
- Provides Power-On Reset for INS8080A Microprocessor
- Synchronizes READY Input to INS8080A Microprocessor
- Provides Oscillator Output for Synchronization of External Circuits
- Reduces System Component Count

#### N8080A Microcomputer Family Block Diagram



Absolute Maximum Ratii	Operating Conditions						
			MIN	MAX	UNITS		
Supply Voltage		Supply Voltage					
Vcc	<sup>1</sup> 7V	Vcc	4.75	5.25	V		
V <sub>DD</sub>	15V	$V_{DD}$	11.4	12.6	V		
Input Voltage	-1V to +5.5V	Temperature (TA)	0	+70	°C		
Storage Temperature Range	-65°C to +150°C						
Maximum Power Dissipation* at 25°C							
Cavity Package	1509 mW						
Molded Package	1476 mW		,				
Lead Temperature (Soldering, 10 seconds)	300°C	•					
*Derate cavity package 10.1 mW/°C above 25 package 11.8 mW/°C above 25°C.	°C; derate molded						

#### Electrical Characteristics (Note 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
lF	Input Current Loading	VF = 0.45V			-0.25	mA
IR	Input Leakage Current	V <sub>R</sub> = 5.25V			10	μΑ
٧c	Input Forward Clamp Voltage	I <sub>C</sub> = -5 mA		-	-1.0	V
VIL	Input "Low" Voltage	V <sub>CC</sub> = 5V			0.8	V
VIH	Input "High" Voltage	RESIN Input	2.6			V
		All Other Inputs	2.0			V
VIH-VIL	RESIN Input Hysteresis	V <sub>CC</sub> = 5V	0.25			V
VOL	Output "Low" Voltage					
	(φ1, φ2), Ready, Reset, STSTB	IOL = 2.5 mA			0.45	V
	Osc., φ2 (TTL)	IOL = 10 mA	-		0.45	V
	Osc., φ2 (TTL)	IOL = 15 mA			0.45	V
Vон	Output "High" Voltage					
	φ1, φ2	I <sub>OH</sub> = -100 μA	9.4			V
	Ready, Reset	I <sub>OH</sub> = -100 μA	3.6			V
	Osc., $\phi$ 2 (TTL), STSTB	I <sub>OH</sub> = −1 mA	2.4			V
I <sub>SC</sub>	Output Short-Circuit Current (All Low Voltage Outputs Only), (Note 1)	V <sub>O</sub> = 0V, V <sub>CC</sub> = 5V	-10		-60	mA
ICC	Power Supply Current				115	mA
IDD	Power Supply Current				12	. mA

Note 1: Caution  $-\phi 1$  and  $\phi 2$  output drivers do not have short circuit protection.

Note 2: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 3: Unless otherwise specified min/max limits apply across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DP8224. All typical values are for  $T_{A} = 25^{\circ}$ C,  $V_{CC} = 5V$ , and  $V_{DD} = 12V$ .

#### **Crystal Requirements\***

Tolerance 0.005% at 0°C to +70°C

Resonance Fundamental\*\*

Equivalent Resistance Power Dissipation (Min) 75 $\Omega$  to 20 $\Omega$ 

Load Capacitance

Fundamental <sup>2</sup> 20 pF to 30 pF

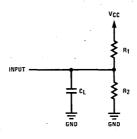
<sup>\*</sup>It is good design practice to ground the case of the crystal

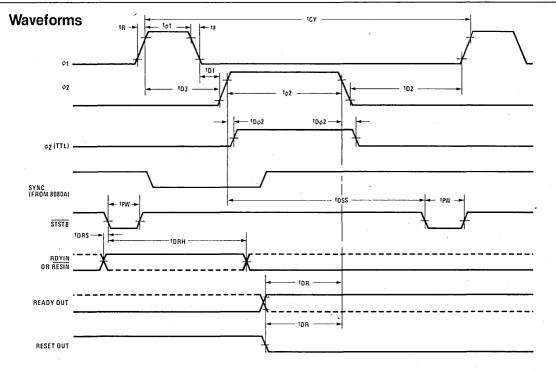
<sup>\*\*</sup>With tank circuit, use 3rd overtone mode

### Switching Characteristics (Note 3)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>φ1</sub>	φ1 Pulse Width	and the second s	$\frac{2t_{CY}}{9} - 20$			ns
t <sub>φ2</sub>	φ2 Pulse Width		5tCY - 35			ns
tD1	φ1 to φ2 Delay		0			ns
tD2	φ2 to φ1 Delay	C <sub>L</sub> = 20 pF to 50 pF	2tCY - 14			ns
t <sub>D3</sub>	φ1 to φ2 Delay		2tCY 9		2tCY 9 + 20	ns
tr	φ1 and φ2 Rise Time	- Ma			20	ns
tf	φ1 and φ2 Fall Time				20	. ns
<sup>t</sup> D¢2	φ2 to φ2 (TTL) Delay	φ2 TTL, C <sub>L</sub> = 30 pF, R1 = 300Ω, R2 = 600Ω	-5		15	ns
tDSS	φ2 to STSTB Delay		$\frac{6t_{CY}}{9} - 30$	-	6tCY 9	ns
tpW	STSTB Pulse Width	STSTB, CL = 15 pF	$\frac{^{\text{tCY}}}{9} - 15$			ns
tDRS	RDYIN Set-Up Time to Status Strobe	R1 = $2 k\Omega$ , R2 = $4 k\Omega$	50 - 4t <sub>CY</sub> 9			ns
<sup>t</sup> DRH	RDYIN Hold Time After STSTB		4tCY 9			ns
tDR	READY or RESET to $\phi2$ Delay	Ready and Reset, $C_L = 10  pF$ , $R1 = 2  k\Omega$ , $R2 = 4  k\Omega$	$\frac{4t_{CY}}{9} - 25$			ns
†CLK	CLK Period			tCY 9		ns
fMAX	Maximum Oscillating Frequency		27			MHz
CIN	Input Capacitance	V <sub>CC</sub> = 5V, V <sub>DD</sub> = 12V, V <sub>BIAS</sub> = 2.5V, f = 1 MHz			8	pF

#### **Test Circuit**





VOLTAGE MEASUREMENT POINTS:  $\phi$ 1,  $\phi$ 2 Logic "0" = 1.0V, Logic "1" = 8.0V. All other signals measured at 1.5V.

#### **Switching Characteristics** (For t<sub>CY</sub> = 488.28 ns)

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
<sup>t</sup> φ1	φ1 Pulse Width		89			ns
tφ2	φ2 Pulse Width	$\phi$ 1 and $\phi$ 2 Loaded to C <sub>L</sub> = 20 to 50 pF Ready & Reset Loaded to 2 mA/10 pF	236			ns
<sup>t</sup> D1	Delay $\phi$ 1 to $\phi$ 2		0			ns
tD2	Delay $\phi$ 2 to $\phi$ 1		95			ns
tD3	Delay $\phi$ 1 to $\phi$ 2 Leading Edges		109		129	ns
t <sub>r</sub>	Output Rise Time				20	ns
tf	Output Fall Time				20	ns
tDSS	φ2 to STSTB Delay	All Measurements Referenced to 1.5V	296	•	326	ns
tD∳2	φ2 to φ2 (TTL) Delay	unless Specified Otherwise	-5		15	ns
tpW	Status Strobe Pulse Width	·	40			nìs
tDRS	RDYIN Set-Up Time to STSTB		-167			ns
<sup>t</sup> DRH	RDYIN Hold Time after STSTB		217			ns
tDR	READY or RESET to $\phi$ 2 Delay		192			ns
fMAX	Oscillator Frequency	•			18.432	MHz

#### **Functional Pin Definitions**

The following describes the function of all of the DP8224 input/output pins. Some of these descriptions reference internal circuits.

#### INPUT SIGNALS

Crystal Connections (XTAL 1 and XTAL 2): Two inputs that connect an external crystal to the oscillator circuit of the DP8224. Normally, a fundamental mode crystal is used to determine the basic operating frequency of the oscillator. However, overtone mode crystals may also be used. The crystal frequency is 9 times the desired microprocessor speed (that is, crystal frequency equals 1/tCY x 9). When the crystal frequency is above 10 MHz, a selected capacitor (3 to 10 pF) may have to be connected in series with the crystal to produce the exact desired frequency. Figure A.

Tank: Allows the use of overtone mode crystals with the oscillator circuit. When an overtone mode crystal is used, the tank input connects to a parallel LC network that is ac coupled to ground. The formula for determining the resonant frequency of this LC network is as follows:

$$F = \frac{1}{2\pi\sqrt{1C}}$$

Synchronizing (SYNC) Signal: When high, indicates the beginning of a new machine cycle. The INS8080A microprocessor outputs a status word (which describes the current machine cycle) onto its data bus during the first state (SYNC interval) of each machine cycle.

Reset In (RESIN): Provides an automatic system reset and start-up upon application of power as follows. The RESIN input, which is obtained from the junction of an external RC network that is connected between V<sub>CC</sub> and ground, is routed to an internal Schmitt Trigger circuit. This circuit converts the slow transition of the power supply rise into a sharp, clean edge when its input reaches a predetermined value. When this occurs, an internal D-type flip-flop is synchronously reset, thereby providing the RESET output signal discussed below.

For manual system reset, a momentary contact switch that provides a low (ground) when closed is also connected to the RESIN input.

Ready In (RDYIN): An asynchronous READY signal that is re-clocked by a D-type flip-flop of the DP8224 to provide the synchronous READY output discussed below.

+5 Volts: V<sub>CC</sub> supply.

+12 Volts: V<sub>DD</sub> supply.

Ground: 0 volt reference.

#### **OUTPUT SIGNALS**

Oscillator (OSC): A buffered oscillator signal that can be used for external timing purposes.

 $\phi_1$  and  $\phi_2$  Clocks: Two non-TTL compatible clock phases that provide nonoverlapping timing references for internal storage elements and logic circuits of the INS8080A microprocessor. The two clock phases are produced by an internal clock generator that consists of a divide-by-nine counter and the associated decode gating logic. Figure B.

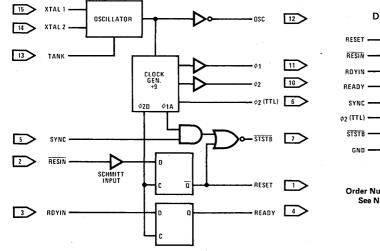
 $\phi_2$  (TTL) Clock: A TTL  $\phi_2$  clock phase that can be used for external timing purposes.

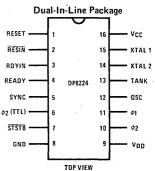
Status Strobe (STSTB): Activated (low) at the start of each new machine cycle. The  $\overline{STSTB}$  signal is generated by gating a high-level SYNC input with the  $\phi_{1A}$  timing signal from the internal clock generator of the DP8224. The  $\overline{STSTB}$  signal is used to clock status information into the status latch of the DP8228 system controller and bus driver.

Reset: When the RESET signal is activated, the content of the program counter of the INS8080A is cleared. After RESET, the program will start at location 0 in memory.

Ready: The READY signal indicates to the INS8080A that valid memory or input data is available. This signal is used to synchronize the INS8080A with slower memory or input/output devices.

#### **Logic and Connection Diagrams**





Order Number DP8224J or DP8224N See NS Package J16A or N16A

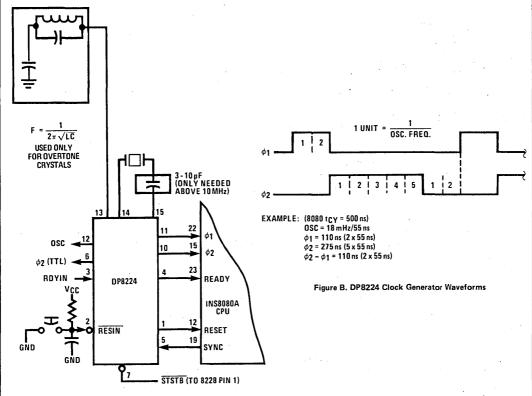


Figure A. DP8224 Connection Diagram

## National Semiconductor

#### **Microprocessor Support**

## DP8228/DP8228M, DP8238/DP8238M System Controller and Bus Driver

#### **General Description**

The DP8228/DP8228M, DP8238/DP8238M are system controller/bus drivers contained in a standard, 28-pin dual-in-line package. The chip, which is fabricated using Schottky Bipolar technology, generates all the read and write control signals required to directly interface the memory and input/output components of National Semiconductor's INS8080A microcomputer family. The chip also provides drive and isolation for the bidirectional data bus of the INS8080A microprocessor. Data bus isolation enables the use of slower memory and input/output components in a system, and provides for enhanced system noise immunity.

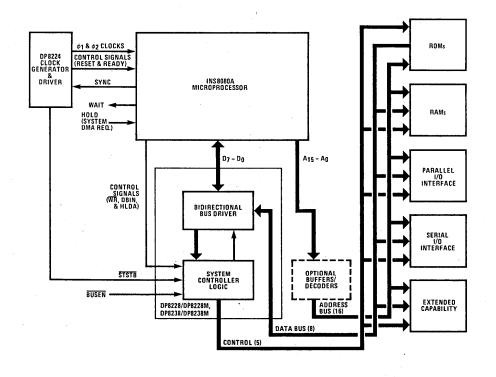
A user-selected single-level interrupt vector (RST 7) is provided by the device for use in the interrupt structure of small systems that need only one basic vector. No additional components (such as an interrupt instruction port) are required to use the single interrupt vector in these systems. The devices also generate an Interrupt Acknowledge (INTA) control signal for each byte of a multibyte CALL instruction when an interrupt is

acknowledged by the INS8080A. This feature permits the use of a multilevel priority interrupt structure in large, interrupt-driven systems.

#### **Features**

- Single Chip System Controller and Bus Driver for INS8080A Microcomputer Systems
- Allows Use of Multibyte CALL Instructions for Interrupt Acknowledge
- Provides User-Selected Single-Level Interrupt Vector (RST 7)
- Provides Isolation for Data Bus
- Supports A Wide Variety of System Bus Structures
- Reduces System Component Count
- DP8238/DP8238M Provides Advanced Input/Output Write and Memory Write Control Signals for Large System Timing Control

#### N8080A Microcomputer Family Block Diagram



#### **Absolute Maximum Ratings**

#### **Operating Conditions**

		•	MIN	MAX	UNITS
Storage Temperature	-65°C to +150°C	Supply Voltage (V <sub>CC</sub> )			
Supply Voltage, VCC	-0.5V to +7V	DP8228M, DP8238M	4.50	5.50	VDC
Input Voltage	-1.5V to +7V	DP8228, DP8238	4.75	5.25	VDC
Output Current	100 mA	Operating Temperature (ΤΔ)			
Maximum Power Dissipation at 25°C		DP8228M, DP8238M	-55	+125	°C
Cavity Package	2179 mW	DP8228, DP8238	0	+70	°c
Molded Package	2361 mW				

<sup>\*</sup>Derate cavity package 14.5 mW/° C above 25° C; derate molded package 18.9 mW/° C above 25° C.

Note: Maximum ratings indicate limits beyond which permanent damage may occur. Continuous operation at these limits is not intended and should be limited to those conditions specified under DC electrical characteristics.

#### **Electrical Characteristics**

(Min  $\leq$  TA  $\leq$  Max, Min  $\leq$  VCC  $\leq$  Max, unless otherwise noted)

	PARAMETER	CONDITIONS		MIN.	TYP (Note 1)	MAX	UNITS
VC	Input Clamp Voltage, All Inputs	VCC = Min, IC = -5 mA			0.6	-1.0	V
IF.	Input Load Current	V <sub>CC</sub> = Max					
	STSTB .	V <sub>F</sub> = 0.45V for DP8228,DP8238				500	μА
	D2 and D6	VF = 0.40V for DP8228M, DP8238M				750	μΑ
	D0, D1, D4, D5 and D7					250	μΑ
	All Other Inputs		j			250	μΑ
IR	Input Leakage Current	V <sub>CC</sub> = Max, V <sub>R</sub> = V <sub>CC</sub>					
	DB0-DB7					20	μΑ
	All Other Inputs					100	μΑ
VTH	Input Threshold Voltage,	Voltage, VCC = 5V		0.8		2.0	V
	All Inputs				,		
Icc	Power Supply Current		DP8228, DP8238		160	190	mA
	•	VCC = Max	DP8228M, DP8238M		160	210	mA
VOL	Output Low Voltage						
	D0-D7	VCC = Min, IOL = 2 mA	DP8228M, DP8238M			0.50	V
		ACC = MIN, IOT = 5 MM	DP8228, DP8238			0.45	V
	All Other Outputs	VCC = Min, IOL = 10 mA	DP8228M, DP8238M			0.50	V
		VCC - WIII, IQL - TO IIIA	DP8228, DP8238			0.45	V
Voн	Output High Voltage	·					
	D0-D7	V <sub>CC</sub> = Min, I <sub>OH</sub> = -10 μA	DP8228M, DP8238M	3.3	3.8		V
,		VCC - MIII, 10H10 μΑ	DP8228, DP8238	3.6	3.8		V
	All Other Outputs	VCC = Min, IOH = -1 mA		2.4	3.8		. V
Ios	Short Circuit Current, All Outputs	V <sub>CC</sub> = 5V, V <sub>O</sub> = 0V		. 15		90	mA
IO(OFF)	OFF State Output Current	VCC = Max, VO = VCC				100	μА
	All Control Outputs	V <sub>CC</sub> = Max, V <sub>O</sub> = 0.45V				-100	μΑ
INT	INTA Current	(See Test Conditions, Figure	3)			5	mA

Note 1: Typical values are for  $T_A = 25^{\circ}C$  and typical supply voltages.

#### Capacitance

 $V_{BIAS}$  = 2.5V,  $V_{CC}$  = 5.0V,  $T_{A}$  = 25°C, f = 1 MHz.

PARAMETER		MIN	TYP (Note 1)	MAX	UNITS
CIN	Input Capacitance		8	12	pF
COUT	Output Capacitance Control Signals		7	15	pF
1/0	I/O Capacitance (D or DB)		8	15	pF

This parameter is periodically sampled and not 100% tested.

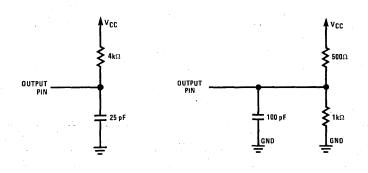
#### **Switching Characteristics**

 $(\mathsf{Min} \leq \mathsf{V}_{\mathsf{CC}} \leq \mathsf{Max}, \mathsf{Min} \leq \mathsf{T}_{\mathsf{A}} \leq \mathsf{Max})$ 

	PARAMETER	CONDITIONS	DP8228M, DP8238M		DP8228, DP8238		UNITS
			MIN	MAX	MIN	MAX	
tpW	Width of Status Strobe		- 25		22		ns
tss	Set-Up Time, Status Inputs D0-D7		8		8		ns
tSH	Hold Time, Status Inputs D0-D7		5		5 .		ns
tDC	Delay from STSTB to Any Control Signal	(Figure 2)	20	75	20	60	ns
tRR	Delay from DBIN to Control Outputs	(Figure 2)		30		30	ns
<sup>t</sup> RE	Delay from DBIN to Enable/ Disable 8080 Bus	(Figure 1)		45		45	ns
<sup>t</sup> RD	Delay from System Bus to 8080 Bus during Read	(Figure 1)		45		30	ns
twR	Delay from WR to Control Outputs	(Figure 2)	5	60	5	45	ns
tWE	Delay to Enable System Bus DB0-DB7 after STSTB	(Figure 2)	,	30		30	ns
tWD	Delay from 8080 Bus D0-D7 to System Bus DB0-DB7 during Write	(Figure 2)	5	40	5	40	ns
tE	Delay from System Bus Enable to System Bus DB0—DB7	(Figure 2)		30		30	ns
tHD	HLDA to Read Status Outputs	(Figure 2)		25		25	ns
<sup>t</sup> DS	Set-Up Time, System Bus Inputs to ḤLDA		10	1	10		ns
tDH	Hold Time, System Bus Inputs to HLDA	<u> </u>	20		20		ns

#### **Test Conditions**

FIGURE 1. Test Load





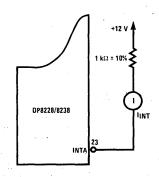
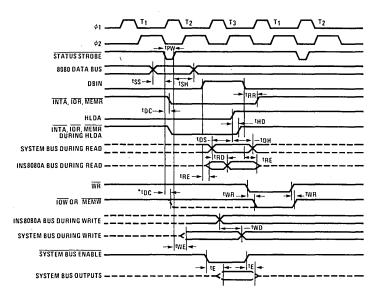


FIGURE 3. INTA Test Circuit (For RST 7)

#### **Timing Diagram**



**VOLTAGE MEASUREMENT POINTS:** D<sub>0</sub> - D<sub>7</sub> (when outputs) Logic "0" = 0.8 V, Logic "1" = 3.0 V. All other signals measured at 1.5 V. \*Advanced I/OW MEMW for 8238 only.

#### **Functional Pin Definitions**

The following describes the function of all of the DP8228/DP8228M, DP8238/DP8238M pinouts. Some of these descriptions reference internal circuits.

#### INPUT SIGNALS

Status Strobe (STSTB): Activated (low) at the start of each new machine cycle. The STSTB input is used to store a status word (refer to chart) from the INS8080A microprocessor into the internal status latch of the DP8228, DP8238. The status word is latched when the STSTB returns to the high state. The INS8080A outputs this status word onto its data bus during the first state (SYNC interval) of each machine cycle.

Data Bus In (DBIN): When high, indicates that the INS8080A data bus is in the input mode. The DBIN signal is used to gate data from memory or an input/output device onto the data bus.

Write (WR): When low, indicates that the data on the INS8080A data bus are stable for WRITE memory or output operation.

Hold Acknowledge (HLDA): When high, indicates that the INS8080A data and address buses will go to their high impedance state. When in the data bus read mode, DBIN input in the high state, a high HLDA input will latch the data bus information into the driver circuits and gate off the applicable control signal I/OR, MEMR, or INTA (return to the output high state).

Bus Enable (BUSEN): Asynchronous DMA input to the internal gating array. When low, normal operation of the internal bidirectional bus driver and gating array occurs. When high, the bus driver and gating array are driven to their high impedance state.

V<sub>CC</sub> Supply: +5 volts.

Ground: 0 volt reference.

#### **OUTPUT SIGNALS**

Memory Read ( $\overline{\text{MEMR}}$ ): When low, signals data to be loaded in from memory. The  $\overline{\text{MEMR}}$  signal is generated by strobing in status word 1, 2, or 4. (Refer to status word chart.)

Memory Write ( $\overline{\text{MEMW}}$ ): When low, signals data to be stored in memory. The  $\overline{\text{MEMW}}$  signal is generated for the DP8238 by strobing in status word 3 or 5. (Refer to status word chart.) For the DP8228, the  $\overline{\text{MEMW}}$  signal is generated by gating a low-level  $\overline{\text{WR}}$  input with the strobed in status word 3 or 5.

Input/Output Read ( $\overline{I/OR}$ ): When low, signals data to be loaded in from an addressed input/output device. The  $\overline{I/OR}$  signal is generated by strobing in status word 6.

Input/Output Write  $\{\overline{I/OW}\}$ : When low, signals data to be transferred to an addressed input/output device. The  $\overline{I/OW}$  signal for the DP8238 is generated by strobing in status word 7. For the DP8228 the  $\overline{I/OW}$  signal is generated by gating in a low-level  $\overline{WR}$  input with the strobed in status word 7.

Interrupt Acknowledge (INTA): When low, indicates that an interrupt has been acknowledged by the INS8080A microprocessor. The INTA signal is generated by strobing in status word 8 or 10.

Single Level Interrupt (RST 7): When the  $\overline{INTA}$  output is tied to 12 V through a 1 k $\Omega$  resistor, strobing in status word 8 or 10 will cause the CPU data bus outputs, when active, to go to the high state.

#### INPUT/OUTPUT SIGNALS

CPU Data (D<sub>7</sub>-D<sub>0</sub>) Bus: This bus comprises eight TRI-STATE input/output lines that connect to the INS8080A microprocessor. The bus provides bidirec-

#### Functional Pin Definitions (Continued)

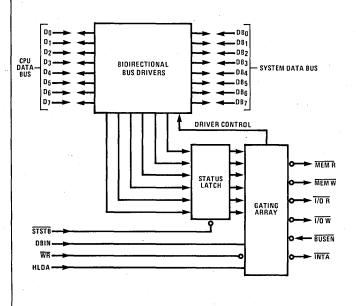
tional communication between the CPU, memory, and input/output devices for instructions and data transfers. A status word (which describes the current machine cycle) is also outputted on this data bus during the first microcycle of each machine cycle (SYNC = logic 1).

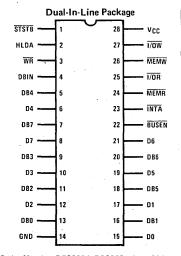
System Data ( $DB_7$ -  $DB_0$ ) Bus: This bus comprises eight TRI-STATE input/output lines that connect to the memory and input/output components of the system. The internal bidirectional bus driver isolates the  $DB_7$ -  $DB_0$  Data Bus from the  $D_7$ -  $D_0$  Data Bus.

**Status Word Chart** 

	Status				Data I	Bus Bit				Control
Machine Cycle	Word	D <sub>7</sub>	D <sub>6</sub>	D <sub>5</sub>	D <sub>4</sub>	D <sub>3</sub>	D <sub>2</sub>	D <sub>1</sub>	D <sub>0</sub>	Signal
Instruction Fetch	1.	1	0	1	0	0	0	1	0.	MEMR
Memory Read	2	1	0	0	0	0	0	1	0	MEMR
Memory Write	3	0	0	0	0	0.	0	0	0 .	MEMW
Stack Read	4 .	1	o	0	0	О	1	1	О	MEMR .
Stack Write	5	0	0	Ō	0	0	1	0	. 0	MEMW
Input Read	- 6	О	1	0	0	0	0	1	0	1/OR
Output Write	7	0	0	0	1	0	0	0	0	I/OW
Interrupt Acknowledge	8	0	0	1	0	0	0	1	1	INTA
Halt Acknowledge	9	1	0	0	0	1	0	1	0	(none)
Interrupt Acknowledge While Halt	10	o	О	1	0	1	. 0	. 1	1	INTA

#### **Block and Connection Diagrams**





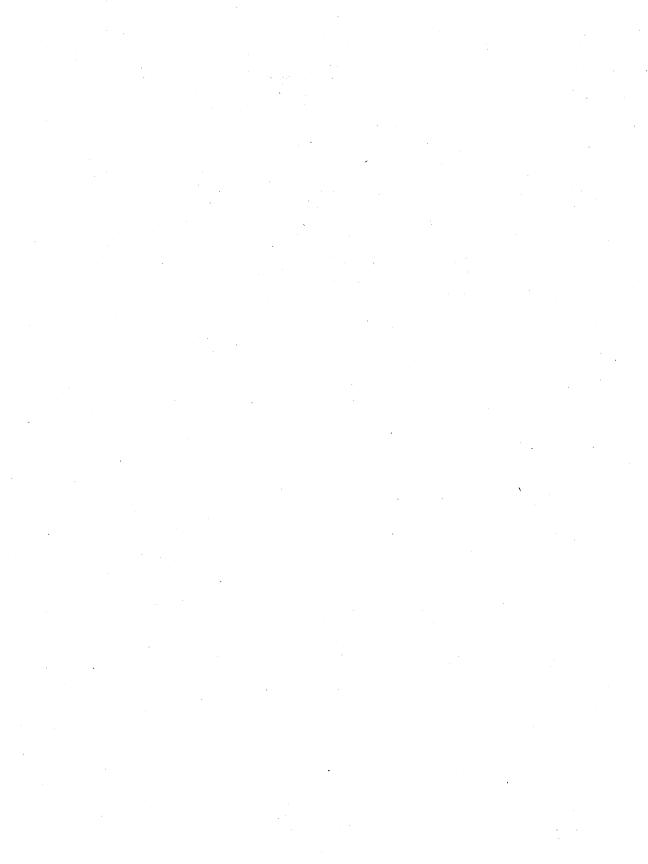
Order Number DP8228J, DP8228MJ, DP8228N, DP8238J, DP8238MJ or DP8238N See NS Package J28A or N28A



# Section 9 Data Communications Support



DEVICE	DESCRIPTION	PAGE NUMBER
DP8340	Serial Bi-Phase Transmitter/Encoder	9-3
DP8341	Serial Bi-Phase Receiver/Decoder	9-12
DP8342	High-Speed Serial Transmitter/Encoder	9-23
DP8343	High-Speed Serial Receiver/Decoder	9-32



#### **Data Communications Support**

#### DP8340 Serial Bi-Phase Transmitter/Encoder

#### **General Description**

The DP8340 generates a complete encoding of parallel data for high speed serial transmission which conforms to the protocol as defined by the IBM 3270 information display system standard. The DP8340 converts parallel input data into a serial data stream. Although the IBM standard covers bi-phase serial data transmission over a coax line, the DP8340 also adapts to general high speed serial data transmission over other than coax lines, at frequencies either higher or lower than the IBM standard.

The DP8340 and its complementary chip, the DP8341 (receiver/decoder) have been designed to provide maximum flexibility in system designs. The separation of the transmitter/receiver functions provides convenient addition of more receivers at one end of a bi-phase line without the need of unused transmitters. This is specifically advantageous in control units where typical bi-phase data is multiplexed over many bi-phase lines and the number of receivers generally exceeds the number of transmitters.

#### **Features**

- Ten bits per data byte transmission
- Single-byte or multi-byte transmission
- Internal parity generation (even or odd)
- Internal crystal controlled oscillator used for the generation of all required chip timing frequencies
- Clock output directly drives receiver (DP8341) clock input
- Input data holding register
- Automatic clear status response feature
- Line drivers at data outputs provide easy interface to bi-phase coax line or general transmission lines
- <2ns driver output skew</p>
- Bipolar technology provides TTL input/output compatibility
- Data outputs power up/down glitch free
- Internal power up clear and reset
- Single +5V power supply

#### Connection Diagram

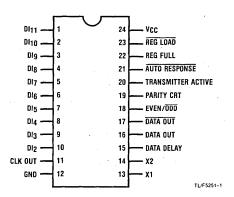


FIGURE 1. Pin-Out Diagram

Order Number DP8340J or DP8340N See NS Package J24A or N24A

#### **Block Diagram**

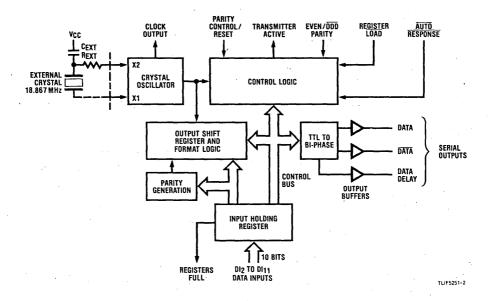


FIGURE 2. DP8340 Serial Bi-Phase Transmitter/Encoder Block Diagram

## **Block Diagram Functional Description**

Figure 2 is a block diagram of the DP8340 Bi-Phase Transmitter/Encoder. The transmitter/encoder contains a crystal oscillator whose input is a crystal with a frequency eight (8) times the data rate. A Clock Output is provided to drive the DP8341 receiver/decoder Clock Input and other system components at the oscillator frequency. Additionally, the oscillator drives the control logic and output shift register/format logic blocks.

Data is parallel loaded from the system data bus to the transmitter/encoder's input holding register. This data is in turn loaded by the transmitter/encoder to its output shift register if this register was empty at the time of the load. During this load, message formatting and parity are generated. The formatted message is then shifted out at the bit rate frequency to the TTL to Bi-Phase block which generates the proper data bit formatting. The three data outputs, DATA, DATA, and DATA DELAY provide for flexible interface to the coax line with a minimum of external components.

The Control Logic block interfaces to all blocks to insure proper chip operation and sequencing. It controls the type of parity generation through the Even/Odd Parity input. An additional feature provided by the transmitter/encoder is generation of odd parity and placement in bit 10 position while still maintaining even or odd parity in

the bit 12 position. This is the format of data word bytes and other commands in the 3270 Standard. The Parity Control input is the pin which controls when this operation is in effect.

Another feature of the transmitter/encoder is the internal TT/AR (Transmission Turnaround/Auto Response) capability. After each Write type message from the control unit in the 3270 Standard, the receiving unit must respond with clean status (bits 2 through 11). With the transmitter/ encoder this function is accomplished simply by forcing the Auto-Response input to the Logic "0" state.

Operation of the transmitter/encoder is automatic. After the first data byte is loaded, the Transmitter Active output is set and the transmitter/encoder immediately formats the input data and serially shifts it out its data outputs. If the message is a multi-byte message, the internal format logic will modify the message data format for multibyte as long as the next byte is loaded to the input holding register before the last data bit of the previous data byte is transferred out of the internal output shift register. After all data is shifted out of the transmitter/encoder the Transmitter Active output will return to the inactive state.

#### **Detailed Pin/Functional Description**

#### Crystal Inputs X1 and X2

The oscillator is controlled by an external, parallel resonant crystal connected between the X1 and X2 pins. Normally, a fundamental mode crystal is used to determine the operating frequency of the oscillator; however, overtone mode crystals may be used.

#### **Crystal Specifications (Parallel Resonant)**

Type AT-cut crystal
Tolerance 0.005% at 25°C
Stability 0.01% from 0°C to +70°C
Resonance Fundamental (Parallel)
Maximum Series Resistance (For 18.867 MHz, 50Ω)
Load Capacitance 15pF

TO PIN X2 PIN (14) CRYSTAL SEE (FIG. 16) >20

FREQ	R	C
<20 MHz	500Ω ±10%	30 pF
>20 MHz	120Ω ±10%	15 pF

#### FIGURE 3. Connection Diagram

TL/F5251-3

If the DP8340 transmitter is clocked by a system clock (crystal oscillator not used), pin 13 (X1 input) should be clocked directly using a Schottky series (74S) circuit. Pin 14 (X2 input) may be left open. The clocking frequency must be set at eight times the data bit rate. Maximum input frequency is 28 MHz. For the IBM 3270 Interface, this frequency is 18.867 MHz. At this frequency, the serial bit rate will be 2.358 Mbits/sec.

#### **Clock Output**

PIN (13)

The Clock Output is a buffered output derived directly from the crystal oscillator block and clocks at the oscillator frequency. It is designed to directly drive the DP8341 receiver/decoder Clock Input as well as other system components.

#### Registers Full

This output is used as a flag by the external operating system. A logic "1" (active state) on this output indicates that both the internal output shift register and the input holding register contain active data. No additional data should be loaded until this output returns to the logic "0" state (inactive state).

#### **Transmitter Active**

This output will be in the logic "1" state while the transmitter/encoder is about to transmit or in the process of transmitting data. Otherwise, it will assume the logic "0" state indicating no data presently in either the input holding or output shift registers.

#### Register Load

The Register Load input is used to load data from the Data Inputs to the input holding register. The loading

function is edge sensitive, the data present during the logic "0" state of this input is loaded, and the input data must be valid before the logic "0" to logic "1" transition. It is after this transition that the transmitter/encoder begins formatting of data for serial transmission.

#### Auto Response (TT/AR)

This input provides for automatic clear data transmission (all bits in logic "0") without the need of loading all zero's. When a logic "0" is forced on this input the transmitter/encoder immediately responds with transmission of "clean status". This function is necessary after the completion of each write type command and in other functions in the 3270 specification. In the logic "1" state the transmitter/encoder transmits data entered on the Data Inputs.

#### Even/Odd Parity

This input sets the internal logic of the DP8340 transmitter/encoder to generate either even or odd parity for the data byte in the bit 12 position. When this pin is in the logic "0" state odd parity is generated. In the logic "1" state even parity is generated. This feature is useful when the control unit is performing a loop back check and at the same time the controller wishes to verify proper data transmission with its receiver/decoder.

#### Parity Control/Reset

Depending on the type of message transmitted, it is at times necessary in the IBM 3270 specification to generate an additional parity bit in the bit 10 position. The bit generated is odd parity on the previous eight (8) bits of data. When the Parity Control input is in the logic "1" state the data entered at the Data Bit 10 position is placed in the transmitted word. With the Parity Control input in the logic "0" state the Data Bit 10 input is ignored and odd parity on the previous data bits is placed in the normal bit 10 position while overall word parity (bit 12) is even or odd (controlled by Even/Odd Parity input). This eliminates the need for external logic to generate the parity on the data bits.

**Truth Table** 

Parity Control Input	Transmitted Data Bit 10
Logic "1"	Data entered on Data Input 10
Logic "0"	Odd Parity on 8-bit data byte

When this input is driven to a voltage that exceeds the power supply level (7V to 13V) the transmitter/encoder is reset.

#### Serial Outputs — DATA, DATA, and DATA DELAY

These three output pins provide for convenient application of data to the Bi-Phase Coax line (see Figure 15 for application). The Data outputs are a direct bit representation of the Bi-Phase data while the DATA DELAY output provides the necessary increment to clearly define the four (4) DC levels of the pulse. The DATA and DATA outputs add flexibility to the DP8340 transmitter/encoder for use in high speed differential line driving applications.

#### Functional Timing Waveforms — Message Format

Single Byte Transmission

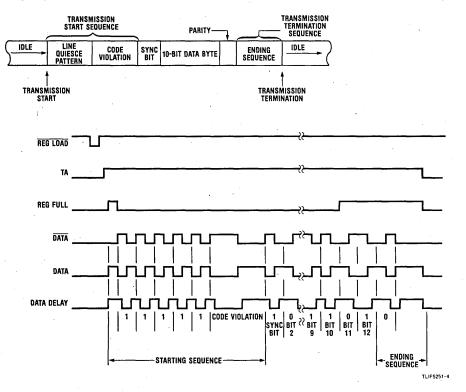
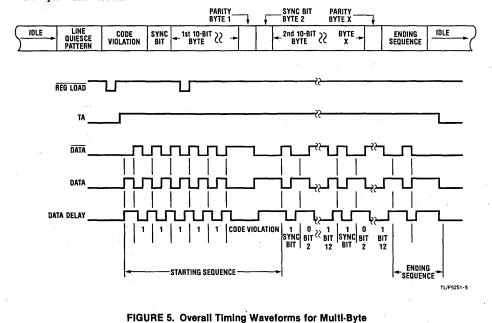


FIGURE 4. Overall Timing Waveforms for Single Byte

#### Multi-Byte Transmission



## Absolute Maximum Ratings (Note 1) Operating Conditions

Supply Voltage, V<sub>CC</sub> 7V
Input Voltage 5.5V
Output Voltage 5.25V
Storage Temperature Range -65°C to 150°C
Lead Temperature (soldering, 10 seconds) 300°C
Maximum Power Dissipation\* at 25°C

Maximum Power Dissipation\* at 25°C
Cavity Package 2237 mW

Molded Package

Supply Voltage, ( $V_{CC}$ ) 4.75 5.25 V Ambient Temperature,  $T_A$  0 +70 °C

### Electrical Characteristics (Notes 2 and 3)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
V <sub>IH</sub>	Logic "1" Input Voltage (All Inputs Except X1 and X2)		2.0			V
V <sub>IL</sub>	Logic "0" Input Voltage (All Inputs Except X1 and X2)	1			0.8	v
V <sub>CLAMP</sub>	Input Clamp Voltage (All Inputs Except X1 and X2)	I <sub>IN</sub> = -12 mA		-0.8	-1.2	v
l <sub>iH</sub> ·	Logic "1" Input Current Register Load Input	$V_{CC} = 5.25V$ $V_{IN} = 5.25V$		0.3	120	μА
	All Others Except X1 and X2			0.1	40	μΑ
I <sub>IL</sub>	Logic "0" Input Current Register Load Input	$V_{CC} = 5.25V$ $V_{IN} = 0.5V$		-15	-300	μΑ
	All Inputs Except X1 and X2			-5	100	μΑ
V <sub>OH1</sub>	Logic "1" All Outputs Except CLK OUT,	$I_{OH} = -100 \mu A$	3.2	3.9		V
	DATA, DATA, and DATA DELAY	I <sub>OH</sub> = -1 mA	2.5	3.4		v
V <sub>OH2</sub>	Logic "1" for CKL OUT, DATA, DATA and DATA DELAY Outputs	I <sub>OH</sub> = -10 mA	2.6	3.0		V
V <sub>OL1</sub>	Logic "0" All Outputs Except CLK OUT, DATA, DATA, and DATA DELAY	I <sub>OL</sub> = 5 mA		0.35	0.5	v
V <sub>OL2</sub>	Logic "0" for CLK OUT, DATA, DATA and DATA DELAY Outputs	I <sub>OL</sub> = 20 mA		0.4	0.6	V
l <sub>os1</sub>	Short Circuit Current for All Outputs Except CLK OUT, DATA, DATA, and DATA DELAY	V <sub>OUT</sub> = 0V Note 4	-10	-30	-100	mA
I <sub>OS2</sub>	Short Circuit Current for DATA, DATA, and DATA DELAY Outputs	V <sub>OUT</sub> = 0V Note 4	-50	-140	-250	mA
I <sub>OS3</sub>	Short Circuit Current for CLK OUT	Note 4	-30	-90	-200	mA
Icc	Power Supply Current	V <sub>CC</sub> = 5.25V		170	250	mA

2500 mW

### Timing Characteristics Oscillator Frequency = 18.867 MHz (Notes 2 and 3)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
t <sub>pd1</sub>	REG LOAD to Transmitter Active (T <sub>A</sub> ) Positive Edge	Load Circuit 1 Figure 7		60	90	ns
t <sub>pd2</sub>	REG LOAD to REG FULL; Positive Edge	Load Circuit 1 Figure 7		45	75	ns
t <sub>pd3</sub>	Register Full to TA; Negative Edge	Load Circuit 1 Figure 7		40	70	ns
t <sub>pd4</sub>	Positive Edge of REG LOAD to Positive Edge of DATA	Load Circuits 1 & 2 Figure 9		50	80	ns
t <sub>pd5</sub>	REG LOAD to DATA; Positive Edge	Load Circuits 1 & 2 Figure 9, Note 6		380	475	ns
t <sub>pd6</sub>	REG LOAD to DATA DELAY; Positive Edge	Load Circuits 1 & 2 Figure 9, Note 6		160	250	ns

<sup>\*</sup>Derate cavity package 14.9 mW/°C above 25°C; derate molded package 20 mW/°C above 25°C.

### Timing Characteristics (Continued) Oscillator Frequency = 18.867 MHz (Notes 2 and 3)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
t <sub>pd7</sub>	Positive Edge of DATA to Negative Edge of DATA DELAY	Load Circuit 2 Figure 9, Note 6		100	115	ns
t <sub>pd8</sub>	Positive Edge of DATA DELAY to Negative Edge of DATA	Load Circuit 2 Figure 9, Note 6		110	125	ns
t <sub>pd9</sub> , t <sub>pd10</sub>	Skew between DATA and DATA	Load Circuit 2 Figure 9		2	6	ns
t <sub>pd11</sub>	Negative Edge of Auto Response to Positive Edge of TA	Load Circuit 1 Figure 10		70	110	ns
t <sub>pd12</sub>	Maximum Time Delay to Load Second Byte After Positive Edge of REG FULL	Load Circuit 1 Figure 8, Note 6			4×T-50	ns
t <sub>pd13</sub>	X1 to CLK OUT; Positive Edge	Load Circuit 2 Figure 13		21	30	ns
t <sub>pd14</sub>	X1 to CLK OUT; Negative Edge	Load Circuit 2 Figure 13		23	33	ns
t <sub>pd15</sub>	Negative Edge of AR to Positive Edge of REG FULL	Load Circuit 1 Figure 10		45	75	ns
t <sub>pd16</sub>	Skew between TA and REG FULL during Auto Response	Load Circuit 1 Figure 10		50	80	ns
t <sub>pd17</sub>	REG LOAD to REG FULL; Positive Edge for Second Byte	Load Circuit 1 Figure 14		45	75	ns
t <sub>pw1</sub>	REG LOAD Pulse Width	Figure 12	40		1	ns
t <sub>pw2</sub>	First REG FULL Pulse Width (note 5)	Load Circuit 1 Figure 7, Note 6		8×T+60	8×T+100	ns
t <sub>pw3</sub>	REG FULL Pulse Width Prior to Ending Sequence(Note 5)	Load Circuit 1, Figure 7, Note 6		5×B		ns
t <sub>pw4</sub>	Pulse Width for Auto Response	Figure 10	40			ns
ts	Data Setup Time prior to REG LOAD Positive Edge. Hold Time (t <sub>H</sub> ) = 0 ns	Figure 12		15	25	ns
t <sub>r1</sub>	Rise Time for DATA, DATA, and DATA DELAY Output Waveform	Load Circuit 2 Figure 11		7	13	ns
t <sub>f1</sub>	Fall Time for DATA, DATA, and DATA DELAY Output Waveform	Load Circuit 2 Figure 11		5	. 11	ns
t <sub>r2</sub>	Rise Time for TA and REG FULL	Load Circuit 1 Figure 15		20	30	ns
t <sub>f2</sub>	Fall Time for TA and REG FULL	Load Circuit 1 Figure 15		15	25	ns
f <sub>MAX</sub>	Data Rate Frequency (Clock Input must be 8X this Frequency)	Note 7	DC		3.5	Mbits/s

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min./max. limits apply across the 0°C to +70°C temperature range and the 4.75V to 5.25V power supply range. All typical values are for  $T_A = 25$ °C and  $V_{CC} = 5.0$ V.

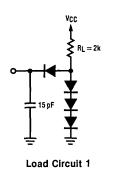
Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max. or min. are so classified on absolute basis.

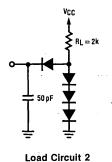
Note 4: Only one output should be shorted at a time.

Note 5: T = 1/(Oscillator Frequency), unit for T should be ns. B = 8T

Note 6: Oscillator Frequency Dependent.

Note 7: For the IBM 3270 Interface, the data rate frequency is 2.358 Mbits/s.





TL/F5251-6

FIGURE 6. Test Load Circuits

### **Timing Waveforms**

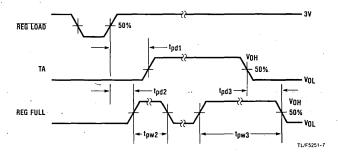


FIGURE 7. Timing Waveforms for Single Byte Transfer

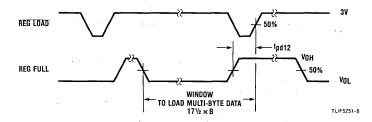


FIGURE 8. Maximum Window to Load Multi-Byte Data

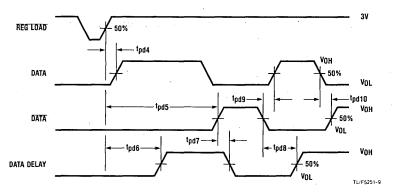


FIGURE 9. Timing Waveforms for Three Serial Outputs

### Timing Waveforms (Continued)

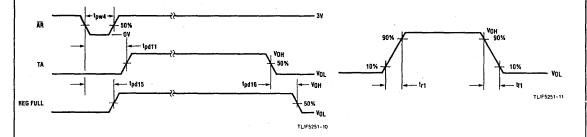
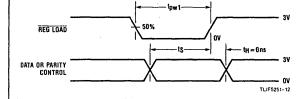


FIGURE 10. Timing Waveforms for Auto-Response

FIGURE 11. Output Waveform for DATA, DATA, DATA DELAY (Load Circuit 2)



CLK OUT 1pd13 0V 0V 1pd14 0V TLUF5251-13

FIGURE 12. Register Load Waveform Requirement

FIGURE 13. Timing Waveforms For Clock Pulse

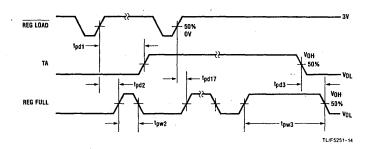


FIGURE 14. Timing Waveforms For Two Byte Transfer

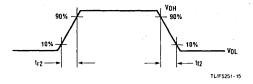


FIGURE 15. Rise and Fall Time Measurement for TA and REG Full

### **Typical Applications**

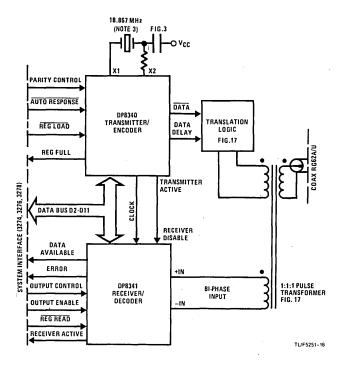
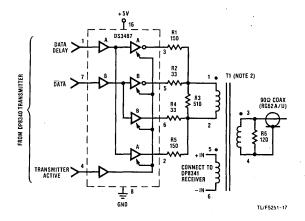


FIGURE 16. Typical Application For IBM 3270 Interface



Notes: 1) Resistance values are in ohms,  $\pm 5\%$ ,  $\frac{1}{4}$  W

- T1 is a 1:1:1 pulse transformer, L<sub>MIN</sub> = 500µH for 18MHz system clock Pulse Engineering Part No. 5763 Technitrol Part No. 11LHA or equivalent transformers
- Crystal manufacturer Midland Ross Corp. NEL Unit Part No. NE-18A @ 18.867 MHz.

FIGURE 17. Translation Logic



# **Data Communications Support**

### DP8341 Serial Bi-Phase Receiver/Decoder

### **General Description**

The DP8341 provides complete decoding of data for high speed serial data communications. In specific, the DP8341 recognizes serial data that conforms to the IBM 3270 Information Display System Standard and converts it into ten (10) bits of parallel data. Although this standard covers Bi-Phase serial data transmission over a coax line, this device easily adapts to generalized high speed serial data transmission on other than coax lines at frequencies either higher or lower than the IBM 3270 standard.

The DP8341 receiver and its complementary chip, the DP8340 transmitter, are designed to provide maximum flexibility in system designs. The separation of transmitter and receiver functions allows addition of more receivers at one end of the Bi-Phase line without the necessity of adding unused transmitters. This is advantageous specifically in control units where typically Bi-Phase data is multiplexed over many Bi-Phase lines and the number of receivers generally outnumber the number of transmitters. The separation of transmitter and receiver function provides an additional advantage in flexibility of data bus organization. The data bus outputs of the receiver are TRI-STATE®, thus enabling the bus configuration to be organized as either a common transmit/ receive (bi-directional) bus or as separate transmit and receive busses for higher speed.

### **Features**

- DP8341 receives ten (10) bit data bytes and conforms to the IBM 3270 Interface Display System Standard
- Separate receiver and transmitter provide maximum system design flexibility
- Even parity detection
- High sensitivity input on receiver easily interfaces to coax line
- Standard TTL data input on receiver provides generalized transmission line interface and also provides hysteresis
- Data holding register
- Multi-byte or single byte transfers
- TRI-STATE receiver data outputs provide flexibility for common or separated transmit/receive data bus operation.
- Data transmission error detection on receiver provides for both error detection and error type definition
- Bi-polar technology provides TTL input/output compatibility with excellent drive characteristics
- Single +5V power supply operation

TRI-STATE® is a registered trademark of National Semiconductor Corp.

### **Connection Diagram**

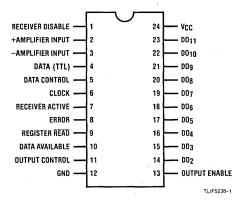


FIGURE 1. Pin Out Diagram

Order Number DP8341J or DP8341N See NS Package J24A or N24A

### **Block Diagram**

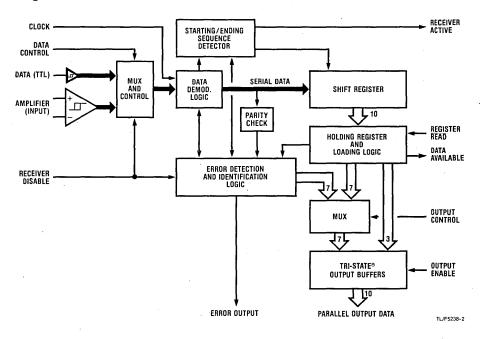


FIGURE 2. DP8341 Serial Bi-Phase Receiver/Decoder Block Diagram

### **Block Diagram Functional Description**

Figure 2 is a block diagram of the DP8341. This chip is essentially a serial in/parallel out shift register. However, the serial input data must conform to a very specific format (see Figures 3-5). The message will not be recognized unless the format of the starting sequence is correct. Deviations from the format in the data, sync bit, parity or ending sequence will cause an error to be detected, terminating the message.

Data enters the receiver through the differential input amplifier or the TTL Data input. The differential amplifier is a high sensitivity input which may be used by connecting it directly to a transformer coupled coax line, or other transmission medium. The TTL Data input provides 400 mV of hysteresis and recognizes TTL logic levels. The data then enters the demodulation block.

The data demodulation block samples the data at eight (8) times the data rate and provides signals for detecting the starting sequence, ending sequence, and errors. Detection of the starting sequence sets the Receiver Active output high and enables the input shift register.

As the ten bits of data are shifted into the shift register, the receiver will verify that even parity is maintained on the data bits and the sync bit. After one complete data byte is received, the contents of the input shift register is parallel loaded to the holding register, assuming the holding register is empty, and the Data Available output is set. If the holding register is full, this load will be delayed until that register has been read. If another data byte is received when the shift register and the holding

register are full a Data Overflow Error will be detected, terminating the message. Data is read from the holding register through the TRI-STATE Output Buffers. The Output Enable input is the TRI-STATE control for these outputs and the Register Read input signals the receiver that the read has been completed.

When the receiver detects an ending sequence the Receiver Active output will be reset to a logic "0" indicating the message has been terminated. A message will also terminate when an error is detected. The Receiver Active output used in conjunction with the Error output allows quick response to the transmitting unit when an error free message has been received.

The Error Detection and Identification block insures that valid data reaches the outputs of the receiver. Detection of an error sets the Error output to a logic "1" and resets the Receiver Active output to a logic "0" terminating the message. The error type may be read from the data bus outputs by setting the Output Control input to logic "0" and enabling the TRI-STATE outputs. The data bit outputs have assigned error definitions (see error code definition table). The Error output will return to a logic "0" when the next starting sequence is received, or when the error is read (Output Control to logic "0" and a Register Read performed).

The Receiver Disable input is used to disable both the amplifier and TTL Data receiver inputs. It will typically be connected directly to the Transmitter Active output of the DP8340 transmitter circuit (see *Figure 12*).

### **Detailed Functional Pin Description**

#### **Receiver Disable**

This input is used to disable the receiver's data inputs. The Receiver Disable input will typically be connected to the Transmitter Active output of the DP8340. However, at the system controller it is necessary for both the transmitter and receiver to be active at the same time in the loop-back check condition. This variation can be accomplished with the addition of minimal external logic.

#### **Truth Table**

Receiver Disable	Data Inputs
Logic "0"	Active
Logic "1"	Disabled

#### **Amplifier Inputs**

The receiver has a differential input amplifier which may be directly connected to the transformer coupled coax line. The amplifier may also be connected to a differential type TTL line. The amplifier has 20 mV of hysteresis.

#### **Data Input**

This input can be used either as an alternate data input or as a power-up check input. If the system designer prefers to use his own amplifier, instead of the one provided on the receiver, then this TTL input may be used. Using this pin as an alternate data input allows self-test of the peripheral system without disturbing the transmission line.

#### **Data Control**

This input is the control pin that selects which of the inputs are used for data entry to the receiver.

**Truth Table** 

Data Control	Data Input To
Logic "0"	Data Input
Logic "1"	Amplifier Inputs

Note: This input is also used for testing. When the inut voltage is raised to  $7.5 \, \text{V}$  the chip resets.

#### Clock Input

This input is the internal clock of the receiver. It must be set at eight (8) times the line data bit rate. For the IBM 3270 Standard, this frequency is 18.87 MHz or a data bit rate of 2.358 MHz. The crystal-controlled oscillator pro-

vided in the DP8340 transmitter also operates at this frequency. The Clock Output of the transmitter is designed to directly drive the receiver's Clock Input. In addition, the receiver is designed to operate correctly to a data bit rate of 3.5 MHz.

#### **Receiver Active**

The purpose of this output is to inform the external system when the DP8341 is in the process of receiving a message. This output will transition to a logic "1" state after the receipt of a valid starting sequence and transition to logic "0" when a valid ending sequence is received or an error is detected. This output combined with the Error output will inform the operating system of the end of an error free data transmission.

#### Error

The Error output transitions to a logic "1" when an error is detected. Detection of an error causes the Receiver Active and the Data Available outputs to transition to a logic "0". The Error output returns to a logic "0" after the error register has been read or when the next starting sequence is detected.

#### **Register Read**

The Register Read input when driven to the logic "0" state signals the receiver that data in the holding register is being read by the external operating system. The data present in the holding register will continue to remain valid until the Register Read input returns to the logic "1" condition. At this time, if an additional byte is present in the input shift register it will be transferred to the holding register, otherwise the data will remain valid in the holding register. The Data Available output will be in the logic "0" state for a short interval while a new byte is transferred to the holding register after a register read.

#### Data Available

This output indicates the existence of a data byte within the output holding register. It may also indicate the presence of a data byte in both the holding register and the input shift register. This output will transition to the logic "1" state as soon as data is available and return to the logic "0" state after each data byte has been read. However, even after the last data byte has been read and the Data Available output has assumed the logic "0" state, the last data byte read from the holding register will remain until new data has been received.

### (

#### **Output Control**

The Output Control input determines the type of information appearing at the data outputs. In the logic "1" state data will appear, in the logic "0" state error codes are present.

#### **Truth Table**

Output Control	Data Outputs
Logic "0"	Error Codes
Logic "1"	Data

#### **Output Enable**

The Output Enable input controls the state of the TRI-STATE Data outputs.

**Truth Table** 

Output Enable	TRI-STATE® Data Outputs
Logic "0"	Disabled
Logic "1"	Active

#### **Data Outputs**

The DP8341 has a ten (10) bit TRI-STATE data bus. Seven bits are multiplexed with error bits. The error bits are de-

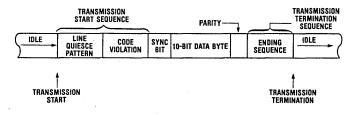
fined in the table below. The Output Control input is the multiplexer control for the Data/Error bits.

#### **Error Code Definition**

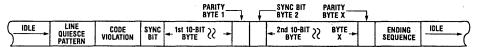
Data Bit	Error Type					
DO2	Data Overflow (Byte not removed from holding register when it and the input shift register are both full and new data is received)					
DO3	Parity Error (Odd parity detected)					
DO4	Transmit Check conditions (existence of errors on any or all of the following data bits: DO3, DO5, and DO6					
DO5	An invalid ending sequence					
DO6	Loss of mid-bit transition detected at other than normal ending sequence time					
DO7	New starting sequence detected before data byte in holding register has been read					
DO8	Receiver disabled during receiver active mode					

### Message Format

#### Single Byte Transmission



#### Multi-Byte Transmission



TL/F5238-3

FIGURE 3. IBM 3270 Message Format

### **Message Format**

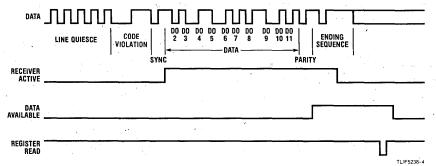
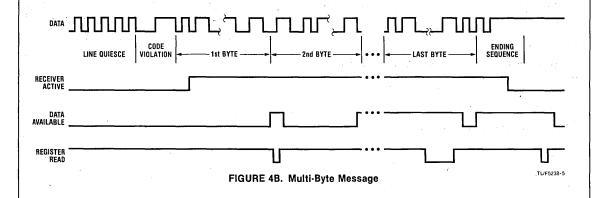
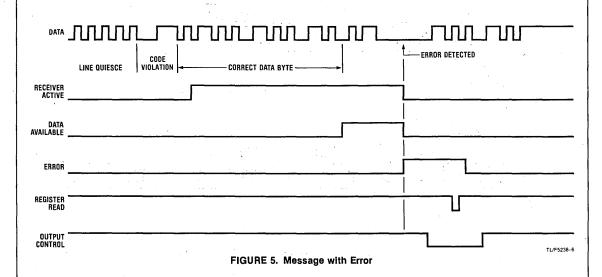


FIGURE 4A. Single Byte Message





### Absolute Maximum Ratings (Note 1)

Supply Voltage, V<sub>CC</sub> 7V
Input Voltage +5.5V
Output Voltage 5.25V
Storage Temperature Range -65°C to 150°C
Lead Temperature (soldering, 10 seconds) 300°C

Maximum Power Dissipation\* at 25°C

Cavity Package 2040 mW Molded Package 2237 mW

### **Operating Conditions**

	MIN.	max.	Units
Supply Voltage, (V <sub>CC</sub> )	4.75	5.25	V
Ambient Temperature, (TA)	0	+70	°C

### Electrical Characteristics (Notes 2, 3, and 5)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	Input High Level		2.0			V
V <sub>IL</sub>	Input Low Level				0.8	٧
VIH-VIL	Data Input Hysteresis (TTL, Pin 4)		0.2	0.4		V
$V_{CLAMP}$	Input Clamp Voltage	I <sub>IN</sub> = -12 mA		-0.8	-1.2	V
l <sub>tH</sub>	Logic "1" Input Current	$V_{CC} = 5.25V, V_{IN} = 5.25V$		2	40	μΑ
l <sup>I</sup> L	Logic "0" Input Current	$V_{CC} = 5.25V, V_{IN} = 0.5V$		-20	-250	μА
VoH	Logic "1" Output Voltage	$I_{OH} = -100 \mu A$	3.2	3.9		V
		I <sub>OH</sub> = -1 mA	2.5	3.2		V
V <sub>OL</sub>	Logic "0" Output Voltage	$I_{OL} = 5  \text{mA}$		0.35	0.5	V
los	Output Short Circuit Current	V <sub>CC</sub> = 5V, V <sub>OUT</sub> = 0V (See Note 4)	-10	-20	-100	mA
loz	TRI-STATE® Output Current	$V_{CC} = 5.25V, V_{O} = 2.5V$	-40	1	+40	μА
	· 	$V_{CC} = 5.25V, V_{O} = 0.5V$	-40	-5	+40	μΑ
A <sub>HYS</sub>	Amplifier Input Hysteresis		5	20	30	· mV
Icc	Power Supply Current	V <sub>CC</sub> = 5.25V		160	250	mA

# Timing Characteristics (Notes 2, 6, 7, and 8)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
T <sub>D1</sub>	Output Data to Data Available Positive Edge		5	20	40	ns
T <sub>D2</sub>	Register Read Positive Edge to Data Available Negative Edge		10	25	45	ns
T <sub>D3</sub>	Error Positive Edge to Data Available Negative Edge		10	30	50	ns
T <sub>D4</sub>	Error Positive Edge to Receiver Active Negative Edge		5	20	40	ns
T <sub>D5</sub>	Register Read Positive Edge to Error Negative Edge		20	45	75	ns
T <sub>D6</sub>	Delay from Output Control to Error Bits from Data Bits		5	20	50	ns
T <sub>D7</sub>	Delay from Output Control to Data Bits from Error Bits		5	20	50	ns
T <sub>D8</sub>	First Sync Bit Positive Edge to Receiver Active Positive Edge			3.5∗T +70		ns
T <sub>D9</sub>	Receiver Active Positive Edge to First Data Available Positive Edge			92 <b>•</b> T		ns
T <sub>D10</sub>	Negative Edge of Ending Sequence to Receiver Active Negative Edge			11.5∗T +50		ns
T <sub>D11</sub>	Data Control Set-up Multiplexer Time Prior to Receiving Data through Selected Input		40	30		ns

<sup>\*</sup> Derate cavity package 13.6 mW/°C above 25°C; derate molded package 17.9 mW/°C above 25°C.

### Timing Characteristics (Cont'd) (Notes 2, 6, 7, and 8)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
T <sub>PW1</sub>	Register Read (Data) Pulse Width		40	30		ns
T <sub>PW2</sub>	Register Read (Error) Pulse Width		40	30		ns
T <sub>PW3</sub>	Data Available Logic "0" State between Data Bytes		25	45		ns
Ts	Output Control Set-up Time Prior to Register Read Negative Edge		0	-5		ns
T <sub>H</sub>	Output Control Hold Time After the Register Read Positive Edge		0	-5		ns
TZE	Delay from Output Enable to Logic "1" or Logic "0" from High Impedance State	Load Circuit 2		25	35	ns
T <sub>EZ</sub>	Delay from Output Enable to High Imped- ance State from Logic "1" or Logic "0"	Load Circuit 2		25	35	ns
F <sub>MAX</sub>	Data Bit Frequency (Clock Input must be 8× the Data Bit Frequency)		DC		3.5	MBits/s

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min. lmax. limits apply across the 0°C to +70°C temperature range and the 4.75V to 5.25V power supply range. All typical values are for  $T_A = 25$ °C and  $V_{CC} = 5.0$ V.

Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max. or min. are so classified on absolute value basis.

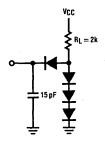
Note 4: Only one output at a time should be shorted.

Note 5: Input characteristics do not apply to amplifier inputs (pins 2 & 3).

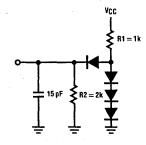
Note 6: Unless otherwise specified, all AC measurements are referenced to the 1.5V level of the input to the 1.5V level of the output and load circuit 1 is used.

Note 7: AC tests are done with input pulses supplied by generators having the following characteristics:  $Z_{OUT} = 50\Omega$  and  $T_f \leqslant 5\,\text{ns.}$   $T_f \leqslant 5\,\text{ns.}$ 

Note 8: T = 1/ (clock input frequency), units for "T" should be ns.



**Load Circuit 1** 



Load Circuit 2

TL/F5238-7

FIGURE 6. Test Load Circuits

# **Timing Waveforms**

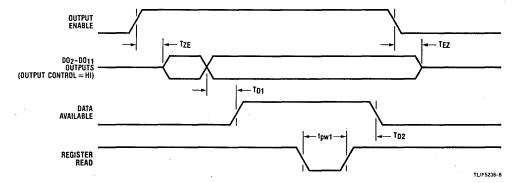


FIGURE 7. Data Sequence Timing

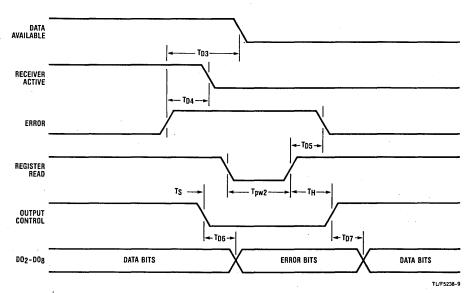


FIGURE 8. Error Sequence Timing

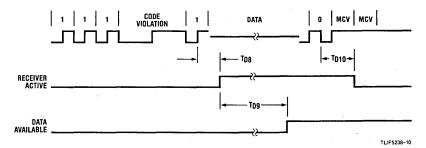


FIGURE 9. Message Timing

# Timing Waveforms (Continued)

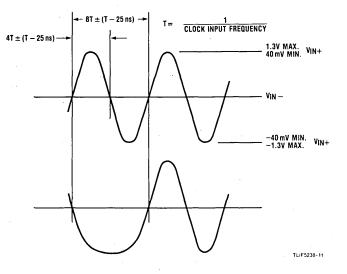


FIGURE 10. Data Waveform Constraints: Amplifier Inputs

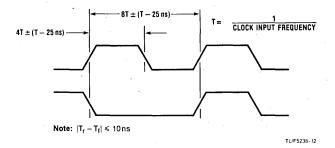
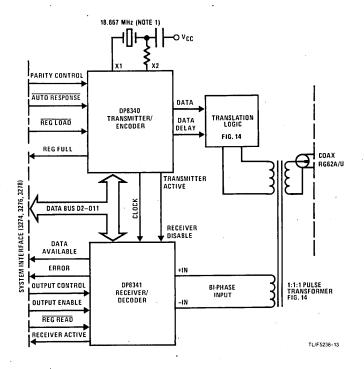


FIGURE 11. Data Waveform Constraints: Data Input (TTL)



Note 1: Crystal manufacturer Midland Ross Corp. NEL Unit Part No. NE18A @ 18.867MHz

FIGURE 12. Typical Application for IBM 3270 Interface

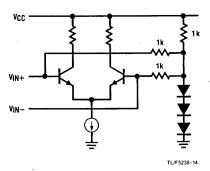
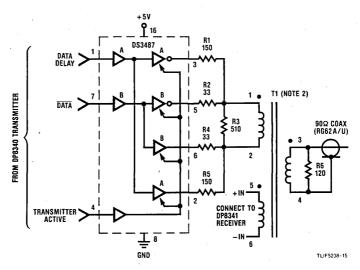


FIGURE 13. Equivalent Circuit for DP8341 Input Amplifier

Q

### Typical Applications (Continued)



Notes: 1) Resistance values are in ohms, ±5%, ¼W
2) T1 is a 1:1:1 pulse transformer, L<sub>MIN</sub> = 500µH for 18MHz system clock
Pulse Engineering Part No. 5762
Technitrol Part No. 11LHA or equivalent transformers

FIGURE 14. Translation Logic

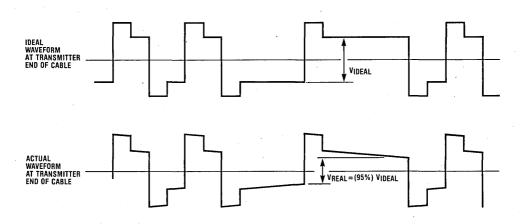


FIGURE 15. Transformer Selection

ICLK = SYSTEM CLOCK FREQUENCY (e.g., 18.87 MHz)

► L(MIN) = 530 µH

\* TO MAINTAIN LOSS AT 95% OF IDEAL SIGNAL, SELECT TRANSFORMER INDUCTANCE SUCH THAT:

L(MIN)=

EXAMPLE:

10,000

18.87 × 106

Notes: 1) Less inductance will cause greater amplitude

effects are generally negligible.

2) Greater inductance may decrease signal rise time slightly and increase ringing, but these

attenuation

# **Data Communications Support**

# DP8342 High-Speed Serial Transmitter/Encoder

### **General Description**

The DP8342 generates a complete encoding of parallel data for high speed serial transmission. It generates a five bit starting sequence, three bit code violation, followed by a syn bit and eight bit per byte of data plus a parity bit. A three-bit ending code signals the termination of the transmission. The DP8342 adapts to generalized high speed serial data transmission as well as the coax lines at a maximum data rate of 3.5 MHz.

The DP8342 and its complementary chip, the DP8343 (receiver/decoder) have been designed to provide maximum flexibility in system designs. The separation of the transmitter/receiver functions provides convenient addition of more receivers at one end of a bi-phase line without the need of unused transmitters. This is specifically advantageous in control units where typical bi-phase data is multiplexed over many bi-phase lines and the number of receivers generally exceeds the number of transmitters.

TRI-STATE® is a registered trademark of National Semiconductor Corp.

### **Features**

- Eight bits per data byte transmission
- Single-byte or multi-byte transmission
- Internal parity generation (even or odd)
- Internal crystal controlled oscillator used for the generation of all required chip timing frequencies
- Clock output directly drives receiver (DP8343) clock
- Input data holding register
- Automatic clear status response feature
- Line drivers at data outputs provide easy interface to bi-phase coax line or general transmission media
- <2ns driver output skew
- Bipolar technology provides TTL input/output compatibility
- Data outputs power up/down glitch free
- Internal power up clear and reset
- Single +5V power supply

### Connection Diagram

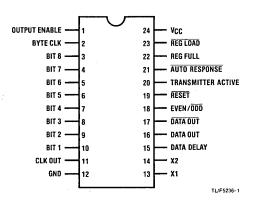


FIGURE 1.

Order Number DP8342J or DP8342N See NS Package J24A or N24A

### **Block Diagram**

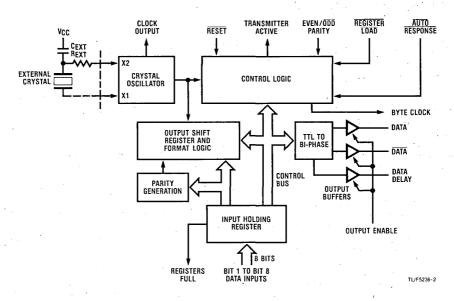


FIGURE 2.

### **Functional Description**

Figure 2 is a block diagram of the DP8342 Bi-Phase Transmitter/Encoder. The transmitter/encoder contains a crystal oscillator whose input is a crystal with a frequency eight (8) times the data rate. A Clock Output is provided to drive the DP8342 receiver/decoder Clock Input and other system components at the oscillator frequency. Additionally, the oscillator drives the control logic and output shift register/format logic blocks.

Data is parallel loaded from the system data bus to the transmitter/encoder's input holding register. This data is in turn loaded by the transmitter/encoder to its output shift register if this register was empty at the time of the load. During this load, message formatting and parity are generated. The formatted message is then shifted out at the bit rate frequency to the TTL to Bi-Phase block which generates the proper data bit formatting. The data outputs, DATA, DATA, and DATA DELAY provide for flexible interface to the transmission medium with little or no external components.

The control Logic block interfaces to all blocks to insure proper chip operation and sequencing. It controls the type of parity generation through the Even/Odd Parity input. An additional feature provided by the transmitter/

encoder is the Reset and Output-TRI-STATE® capability. Another feature of the DP8342 is the Byte Clock output which keeps track of the number of bytes transferred.

The transmitter/encoder is also capable of internal TT/AR (Transmission Turnaround/Auto Response). When the Auto-Response (AR) input is forced to the logic "0" state, the transmitter/encoder responds with clean status (all zeros on data bits).

Operation of the transmitter/encoder is automatic. After the first data byte is loaded, the Transmitter Active output is set and the transmitter/encoder immediately formats the input data and serially shifts it out its data outputs. If the message is a multi-byte message, the internal format logic will modify the message data format for multibyte as long as the next byte is loaded to the input holding format logic will modify the message data format for multibyte as long as the next byte is loaded to the input holding register before the last data bit of the previous data byte is transferred out of the internal output shift register. After all data is shifted out of the transmitter/encoder the Transmitter Active output will return to the inactive state.

# 0

### **Detailed Pin/Functional Description**

#### Crystal Inputs X1 and X2

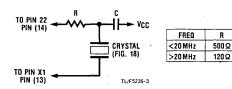
The oscillator is controlled by an external, parallel resonant crystal connected between the X1 and X2 pins. Normally, a fundamental mode crystal is used to determine the operating frequency of the oscillator; however, overtone mode crystals may be used.

#### Crystal Specifications (Parallel Resonant)

Type  $<20\,\text{MHz}$  AT-cut or  $>20\,\text{MHz}$  BT-cut Tolerance 0.005% at 25 °C Stability 0.01% from 0 °C to +70 °C Resonance Fundamental (Parallel) Maximum Series Resistance Dependent on Frequency (For  $20\,\text{MHz}$ ,  $50\Omega$ )

Load Capacitance 15pF

### **Connection Diagram**



If the DP8342 transmitter is clocked by a system clock (crystal oscillator not used), pin 13 (X1 input) should be clocked directly using a Schottky series (74S) circuit. Pin 14 (X2 input) may be left open. The clocking frequency must be set at eight times the data bit rate. Maximum input frequency is 28 MHz.

#### **Clock Output**

The Clock Output is a buffered output derived directly from the crystal oscillator block and clocks at the oscillator frequency. It is designed to directly drive the DP8343 receiver/decoder Clock Input as well as other system components.

#### Registers Full

This output is used as a flag by the external operating system. A logic "1" (active state) on this output indicates that both the internal output shift register and the input holding register contain active data. No additional data should be loaded until this output returns to the logic "0" state (inactive state).

#### **Transmitter Active**

This output will be in the logic "1" state while the transmitter/encoder is about to transmit or in the process of transmitting data. Otherwise, it will assume the logic "0" state indicating no data presently in either the input holding or output shift registers.

#### Register Load

The Register Load input is used to load data from the Data Inputs to the input holding register. The loading function is level sensitive, the data present during the logic "0" state of this input is loaded, and the input data must be valid before the logic "0" to logic "1" transition. It is after this transition that the transmitter/encoder begins formatting of data for serial transmission.

#### Auto Response (TT/AR)

This input provides for automatic clear data transmission (all bits in logic "0") without the need of loading all zero's. When a logic "0" is forced on this input the transmitter/encoder immediately responds with transmission of "clean status". When this input is in the logic "1" state the transmitter/encoder transmits data entered on the Data Inputs.

#### Even/Odd Parity

C

30 pF

15 pF

This input sets the internal logic of the DP8342 transmitter/encoder to generate either even or odd parity for the data byte in the bit 10 position. When this pin is in the logic "0" state odd parity is generated. In the logic "1" state even parity is generated. This feature is useful when the control unit is performing a loop back check and at the same time the controller wishes to verify proper data transmission with its receiver/decoder.

### Serial Outputs - DATA, DATA, and DATA DELAY

These three output pins provide for convenient application of data to the Bi-Phase transmission line. The Data outputs are a direct bit representation of the Bi-Phase data while the Data Delay output provides the necessary increment to clearly define the four (4) DC levels of the pulse. The DATA and DATA outputs add flexibility to the DP8342 transmitter/encoder for use in high speed differential line driving applications. The typical DATA to DATA skew is 2ns.

#### RESET

When a logic "0" is forced on this input, all outputs except Clock Output are latched low.

#### **Output Enable**

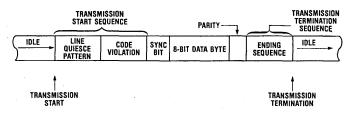
When a logic "0" is forced on this input the three serial data outputs are in the high impedance state.

#### Byte Clock

This pin registers a pulse at the end of each byte transmission. The number of pulses registered corresponds to the number of bytes transmitted.

### **Message Format**

Single Byte Transmission



#### **Multi-Byte Transmission**

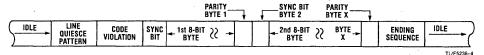


FIGURE 3.

## **Functional Timing Waveforms**

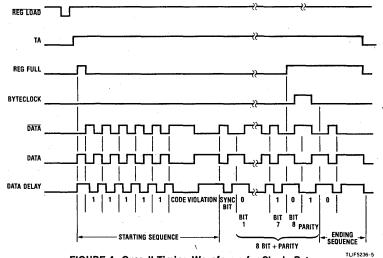


FIGURE 4. Overall Timing Waveforms for Single Byte

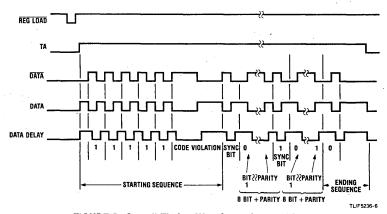


FIGURE 5. Overall Timing Waveforms for Multi-Byte

# Absolute Maximum Ratings (Note 1) Supply Voltage, Vcc

Input Voltage 5.5V **Output Voltage** 5.25V Storage Temperature Range -65°C to +150°C 300°C

Lead Temperature (soldering, 10 seconds) Maximum Power Dissipation\* at 25°C

Cavity Package 2237 mW Molded Package 2500 mW

\* Derate cavity package 14.9 mW/\*C above 25\*C; derate molded package 20 mW/\*C above 25\*C.

Min. Units Max. Supply Voltage, (V<sub>CC</sub>) 4.75 5.25 ٧ Ambient Temperature, TA 0 +70 °C

**Operating Conditions** 

### Electrical Characteristics (Notes 2 and 3)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	Logic "1" Input Voltage (All Inputs Except X1 and X2)	V <sub>CC</sub> = 5V	2.0			V
V <sub>IL</sub>	Logic "0" Input Voltage (All Inputs Except X1 and X2)	V <sub>CC</sub> = 5V			0.8	v
V <sub>CLAMP</sub>	Input Clamp Voltage (All Inputs Except X1 and X2)	I <sub>IN</sub> = -12 mA		-0.8	-1.2	v
l <sub>ін</sub>	Logic "1" Input Current Register Load Input	$V_{CC} = 5.25V$ $V_{IN} = 5.25V$		0.3	120	μА
	All Others Except X1 and X2	- 111		0.1	0.8	μA
ايل	Logic "0" Input Current Register Load Input	$V_{CC} = 5.25V$ $V_{IN} = 0.5V$		-15	-300	μА
	All Inputs Except X1 and X2	VIN = 0.5 V		-5	-100	μΑ
V <sub>OH1</sub>	Logic "1" All Outputs Except CLK OUT, DATA, DATA, and DATA DELAY	$I_{OH} = -100 \mu A$ $V_{CC} = 4.75 V$	3.2	3.9		v
		I <sub>OH</sub> = −1 mA	2.5	3.4	,	V
V <sub>OH2</sub>	Logic "1" for CKL OUT, DATA, DATA and DATA DELAY Outputs	$V_{CC} = 4.75V$ , $I_{OH} = -10 \text{ mA}$	2.6	3.0		v
V <sub>OL1</sub>	Logic "0" All Outputs Except CLK OUT, DATA, DATA, and DATA DELAY	$V_{CC} = 4.75V$ $I_{OL} = 5 \text{ mA}$		0.35	0.5	· v
V <sub>OL2</sub>	Logic "0" for CLK OUT, DATA, DATA and DATA DELAY Outputs	V <sub>CC</sub> = 4.75V I <sub>OL</sub> = 20 mA		0.4	0.6	v
I <sub>OS1</sub>	Output Short Circuit Current for All Except CLK OUT, DATA, DATA, and DATA DELAY Outputs	Note 5 V <sub>OUT</sub> = 0V	-10	-30	-100	mA
I <sub>OS2</sub>	Output Short Circuit Current DATA, DATA, and DATA DELAY Outputs	Note 5 V <sub>OUT</sub> = 0V	-50	-140	-250	mA
I <sub>OS3</sub>	Output Short Circuit Current for CLK OUT	Note 5 V <sub>OUT</sub> = 0V	-30	-90	-200	mA
Icc	Power Supply Current	V <sub>CC</sub> = 5.25V		170	250	mA

# Timing Characteristics $V_{CC} = 5V \pm 5\%$ , $T_A = 0^{\circ}C$ to 70°C, Oscillator Frequency = 28 MHz (Notes 2 and 3)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t <sub>pd1</sub>	REG LOAD to Transmitter Active (T <sub>A</sub> ) Positive Edge	Load Circuit 1 Figure 6		60	90	ns
t <sub>pd2</sub>	REG LOAD to Register Full; Positive Edge	Load Circuit 1 Figure 6		45	75	ns
t <sub>pd3</sub>	T <sub>A</sub> to Register Full; Negative Edge	Load Circuit 1 Figure 6		40	70	ns
t <sub>pd4</sub>	Positive Edge of REG LOAD to Positive Edge of DATA	Load Circuit 2 Figure 9	,	50	80	ns
t <sub>pd5</sub>	REG LOAD to DATA; Positive Edge	Load Circuit 2 Figure 9		280	380	ns
t <sub>pd6</sub>	REG LOAD to DATA DELAY; Positive Edge	Load Circuit 2 Figure 9		150	240	ns
t <sub>pd7</sub>	Positive Edge of DATA to Negative Edge of DATA DELAY	Load Circuit 2 Figure 9		70	85	ns

Timing Characteristics (Continued) Oscillator Frequency = 28MHz (Notes 2 and 3)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t <sub>pd8</sub>	Positive Edge of DATA DELAY to Negative Edge of DATA	Load Circuit 2 Figure 9		80	95	ns
t <sub>pd9</sub> , t <sub>pd10</sub> )	Skew between DATA and DATA	Load Circuit 2 Figure 9		2	6	ns
t <sub>pd11</sub>	Negative Edge of Auto Response (AR) to Positive Edge of TA	Load Circuit 1 Figure 10		70	100	ns
t <sub>pd12</sub>	Maximum Time Delay to Load Second Byte After Positive Edge of REG FULL	Load Circuit 1 Figure 8, Note 7			4×T-50	ns
t <sub>pd13</sub>	X1 to CLK OUT; Positive Edge	Load Circuit 2 Figure 11		21	30	ns
t <sub>pd14</sub>	X1 to CLK OUT; Negative Edge	Load Circuit 2 Figure 11		23	33	ns
t <sub>pd15</sub>	Negative Edge of AR to Positive Edge of REG FULL	Load Circuit 1 Figure 10		45	75	ns
t <sub>pd16</sub>	Skew between TA and REG FULL during Auto Response	Load Circuit 1 Figure 10		50	80	ns
t <sub>pd17</sub>	REG LOAD to REG FULL; Positive Edge for Second Byte	Load Circuit 1 Figure 7		45	75	ns
t <sub>pd18</sub>	REG FULL to BYTE CLK; Negative Edge	Load Circuit 1 Figure 7		60	90	ns
t <sub>pd19</sub>	REG FULL to BYTE CLK; Positive Edge	Load Circuit 1 Figure 7		145	180	ns
t <sub>ZH</sub>	Output Enable to DATA, DATA, or DATA Delay outputs: HiZ to High	CL = 50 pF Figures 17, 17		25	45	ns
t <sub>ZL</sub>	Output Enable to DATA, DATA, OR DATA Delay Outputs; HiZ to High	CL = 50 pF Figures 16, 17		15	30	ns
t <sub>HZ</sub>	Output Enable to DATA, DATA, or DATA  Delay Outputs; High to HiZ	CL=15pF Figures 16, 17		65	100	ns
t <sub>LZ</sub>	Output Enable to DATA, DATA, or DATA Delay Outputs; Low to HiZ	CL = 15pF Figures 16, 17		45	70	ns
t <sub>pw1</sub>	REG LOAD Pulse Width	Figure 12	40			ns
t <sub>pw2</sub>	First REG FULL Pulse Width (Note 6)	Load Circuit 1 Figure 7, Note 7		8×T+60	8×T+100	ns
t <sub>pw3</sub>	REG FULL Pulse Width Prior to Ending Sequence (Note 6)	Load Circuit 1 Figure 7		5×B		ns
t <sub>pw4</sub>	Pulse Width for Auto Response	Figure 10	40			ns
t <sub>pw5</sub>	Pulse Width for BYTE CLK	Load Circuit 1 Figure 7, Note 7		8×T+30	8×T+80	ns
t <sub>s</sub>	Data Setup Time prior to REG LOAD Positive Edge. Hold Time = 0 ns	Figure 12		15	23	ns
t <sub>r1</sub>	Rise Time for DATA, DATA, and DATA DELAY Output Waveform	Load Circuit 2, Figure 13		7	13	ns
t <sub>f1</sub>	Fall Time for DATA, DATA, and DATA DELAY Output Waveform	Load Circuit 2, Figure 13		5	11	ns
t <sub>r2</sub>	Rise Time for TA and REG FULL	Load Circuit 1 Figure 14		20	30	ns
t <sub>f2</sub>	Fall Time for TA and REG FULL	Load Circuit 1 Figure 14		15	25	ns
f <sub>MAX</sub>	Data Rate Frequency (Clock Input must be 8X this Frequency)		DC		3.5	Mbits/s
CIN	Input Capacitance — Any Input	Note 4	1	5	15	pF

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min./max. limits apply across the 0°C to +70°C temperature range and the 4.75V to 5.25V power supply range. All typical values are for T<sub>A</sub> = 25°C and V<sub>CC</sub> = 5.0V.

Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max. or min. are so classified on absolute basis.

Note 4: Input capacitance is guaranteed by periodic testing.  $f_{TEST} = 10 \, kHz$  at 300 mV,  $T_A = 25^{\circ}C$ .

Note 5: Only one output should be shorted at a time.

Note 6: T = 1/(Oscillator Frequency). Unit for T should be in ns. B = 8T.

Note 7: Oscillator Frequency Dependent.

### Timing Waveforms (Continued)

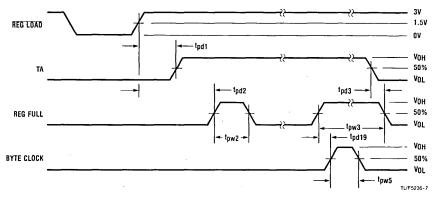


FIGURE 6. Single Byte Transfer

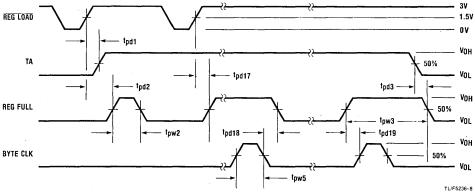


FIGURE 7. Two-Byte Transfer

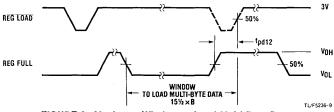


FIGURE 8. Maximum Window to Load Multi-Byte Data

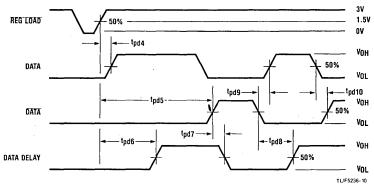


FIGURE 9. Three Serial Outputs

### Timing Waveforms (Continued)

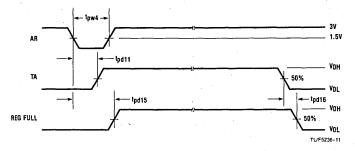


FIGURE 10. Auto-Response

FIGURE 11. Clock Pulse

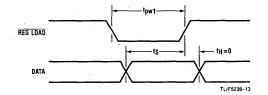


FIGURE 12. REG LOAD

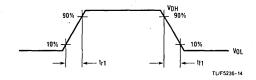


FIGURE 13. Output Waveform for DATA, DATA, DATA DELAY (Load Circuit 2)

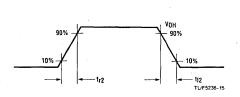


FIGURE 14. Rise and Fall Time Measurement for TA and REG FULL

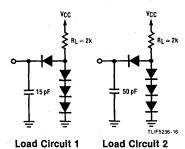


FIGURE 15. Test Load Circuits

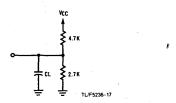


FIGURE 16. Load Circuit for Output TRI-STATE Test

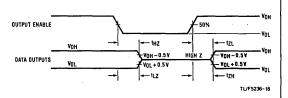


FIGURE 17. TRI-STATE Test

### **Typical Applications**

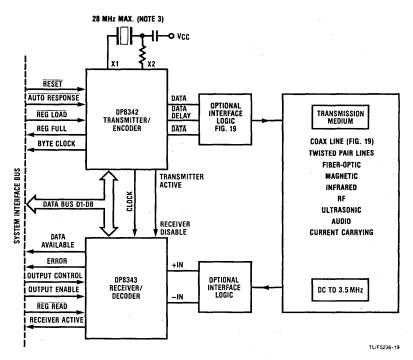
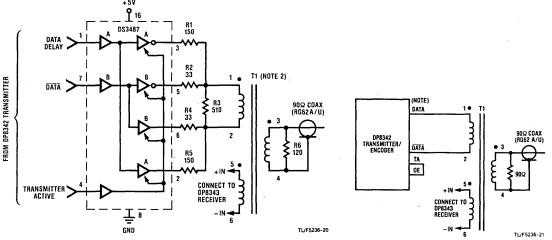


FIGURE 18.



Notes: 1) Resistance values are in ohms, ±5%, ¼ W

- 2) T1 is a 1:1:1 pulse transformer, L =  $500\,\mu\text{H}$  for 18 to 28MHz system clock. Pulse Engineering Part No. 5762
- Technitrol Part No. 11LHA or equivalent transformer
  3) Crystal manufacturer Midland Ross Corp. NEL Unit Part No. NE-18A @ 28MHz.

FIGURE 19. Interface Logic for a Coax Transmission Line

Note: Data rates up to 3.5 Mbits/s at 5000ft still apply.

FIGURE 20. Direct Interface for a Coax Transmission Line (Non-IBM Voltage Levels)

# **Data Communications Support**

# DP8343 High-Speed Serial Receiver/Decoder

### **General Description**

The DP8343 provides complete decoding of data for high speed serial data communications. In specific, the DP8343 receiver recognizes Bi-Phase serial data sent from its complementary chip, the DP8342 transmitter, and converts it into eight (8) bits of parallel data. These devices are easily adapted to generalized high speed serial data transmission systems that operate at bit rates up to 3.5 MHz.

The DP8343 receiver and the DP8342 transmitter are designed to provide maximum flexibility in system designs. The separation of transmitter and receiver functions allows addition of more receivers at one end of the Bi-Phase line without the necessity of adding unused transmitters. This is advantageous in control units where the data is typically multiplexed over many lines and the number of receivers generally exceeds the number of transmitters. The separation of transmitter and receiver function provides an additional advantage in flexibility of data bus organization. The data bus outputs of the receiver are TRI-STATE®, thus enabling the bus configuration to be organized as either a common transmit/receive (bi-directional) bus or as separate transmit and receive busses for higher speed.

#### **Features**

- DP8343 receives eight (8) bit data bytes
- Separate receiver and transmitter provide maximum system design flexibility
- Even parity detection
- High sensitivity input on receiver easily interfaces to coax line
- Standard TTL data input on receiver provides generalized transmission line interface and also provides hysteresis
- Data holding register
- Multi-byte or single byte transfers
- TRI-STATE receiver date outputs provide flexibility for common or separated transmit/receive data bus operation
- Data transmission error detection on receiver provides for both error detection and error type definition
- Bipolar technology provides TTL input/output compatibility with excellent drive characteristics
- Single +5V power supply operation

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### Connection Diagram

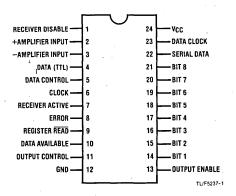


FIGURE 1.

Order Number DP8343J or DP8343N See NS Package J24A or N24A

### Block Diagram

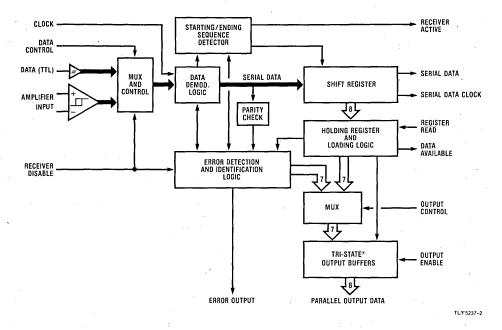


FIGURE 2. DP8343 Bi-Phase Receiver

### **Block Diagram Functional Description**

Figure 2 is a block diagram of the DP8343 receiver. This chip is essentially a serial in/parallel out shift register. However, the serial input data must conform to a very specific format (see Figures 3-6). The message will not be recognized unless the format of the starting sequence is correct. Deviations from the format in the data, sync bit, parity or ending sequence will cause an error to be detected, terminating the message.

Data enters the receiver through the differential input amplifier or the TTL Data input. The differential amplifier is a high sensitivity input which may be used by connecting it directly to a transformer coupled coax line, or other transmission medium. The TTL Data input provides 400 mV of hysteresis and recognizes TTL logic levels. The data then enters the demodulation block.

The data demodulation block samples the data at eight (8) times the data rate and provides signals for detecting the starting sequence, ending sequence, and errors. Detection of the starting sequence sets the Receiver Active output high and enables the input shift register.

As the eight bits of data are shifted into the shift register, the receiver will verify that even parity is maintained on the data bits and the sync bit. Serial Data and Serial Data Clock, the inputs to the shift register, are provided for use with external error detecting schemes. After one complete data byte is received, the contents of the input shift register is parallel loaded to the holding register, assuming the holding register is empty, and the Data Available output is set. If the holding register is full, this load will be delayed until that register has been read or

the start of another data byte is received, in which case a Data Overflow Error will be detected, terminating the message. Data is read from the holding register through the TRI-STATE Output Buffers. The Output Enable input is the TRI-STATE control for these outputs and the Register Read input signals the receiver that the read has been completed.

When the receiver detects an ending sequence the Receiver Active output will be reset to a logic "0" indicating the message has been terminated. A message will also terminate when an error is detected. The Receiver Active output used in conjunction with the Error output allows quick response to the transmitting unit when an error free message has been received.

The Error Detection and Identification block insures that valid data reaches the outputs of the receiver. Detection of an error sets the Error output to a logic "1" and resets the Receiver Active output to a logic "0" terminating the message. The error type may be read from the data bus outputs by setting the Output Control input to logic "0" and enabling the TRI-STATE outputs. The data bit outputs have assigned error definitions (see error code definition table). The Error output will return to a logic "0" when the next starting sequence is received, or when the error is read (Output Control to logic "0" and a Register Read performed).

The Receiver Disable input is used to disable both the amplifier and TTL Data receiver inputs. It will typically be connected directly to the Transmitter Active output of the DP8342 transmitter circuit.

### **Detailed Functional Pin Description**

#### **Receiver Disable**

This input is used to disable the receiver's data inputs. The Receiver Disable input will typically be connected to the Transmitter Active output of the DP8342. However, at the system controller it may be necessary for both the transmitter and receiver to be active at the same time. This variation can be accomplished with the addition of minimal external logic.

**Truth Table** 

Receiver Disable	Data Inputs
Logic "0"	Active
Logic "1"	Disabled

#### **Amplifier Inputs**

The receiver has a differential input amplifier which may be directly connected to the transformer coupled coax line. The amplifier may also be connected to a differential type TTL line. The amplifier has 20 mV of hysteresis.

#### **Data Input**

This input can be used either as an alternate data input or as a power-up check input. If the system designer prefers to use his own amplifier, instead of the one provided on the receiver, then this TTL input may be used. Using this pin as an alternate data input allows self-test of the peripheral system without disturbing the transmission line.

#### **Data Control**

This input is the control pin that selects which of the inputs are used for data entry to the receiver.

**Truth Table** 

Data Control	Data Input To
Logic "0"	Data Input
Logic "1"	Amplifier Input

Note: This input is also used for testing. When the input voltage is raised to 7.5V the chip resets.

#### **Clock Input**

This input is the internal clock of the receiver. It must be set at eight (8) times the line data bit rate. The crystal-controlled oscillator provided in the DP8342 transmitter also operates at this frequency. The Clock Output of the transmitter is designed to directly drive the receiver's Clock Input. In addition, the receiver is designed to operate correctly to a data bit rate of 3.5 MHz.

#### **Receiver Active**

The purpose of this output is to inform the external system when the DP8343 is in the process of receiving a message. This output will transition to a logic "1" state after a receipt of a valid starting sequence and transition to logic "0" when a valid ending sequence is received or an error is detected. This output combined with the Error output will inform the operating system of the end of an error free data transmission.

#### Frror

The Error output transitions to a logic "1" when an error is detected. Detection of an error causes the Receiver Active and the Data Available outputs to transition to a logic "0". The Error output returns to a logic "0" after the error register has been read or when the next starting sequence is detected.

#### Register Read

The Register Read input when driven to the logic "0" state signals the receiver that data in the holding register is being read by the external operating system. The data present in the holding register will continue to remain valid until the Register Read input returns to the logic "1" condition. At this time, if an additional byte is present in the input shift register it will be transferred to the holding register, otherwise the data will remain valid in the holding register. The Data Available output will be in the logic "0" state for a short interval while a new byte is transferred to the holding register after a register read.

#### Data Available

This output indicates the existence of a data byte within the output holding register. It may also indicate the presence of a data byte in both the holding register and the input shift register. This output will transition to the logic "1" state as soon as data is available and return to the logic "0" state after each data byte has been read. However, even after the last data byte has been read and the Data Available output has assumed the logic "0" state, the last data byte read from the holding register will remain until new data has been received.

#### **Output Control**

The Output Control input determines the type of information appearing at the data outputs. In the logic "1" state data will appear, in the logic "0" state error codes are present.

Truth Table

Output Control	Data Outputs
Logic "0"	Error Codes
Logic "1"	Data

#### **Output Enable**

The Output Enable input controls the state of the TRI-STATE Data outputs.

**Truth Table** 

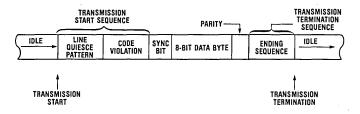
Output Enable	TRI-STATE Data Outputs
Logic "0"	Disabled
Logic "1"	Active

#### **Data Outputs**

The DP8343 has an eight (8) bit TRI-STATE data bus. Seven bits are multiplexed with error bits. The error bits are defined in the table below. The Output Control input is the multiplexer control for the Data/Error bits.

### **Message Format**

Single Byte Transmission



Multi-Byte Transmission

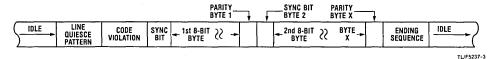


FIGURE 3.

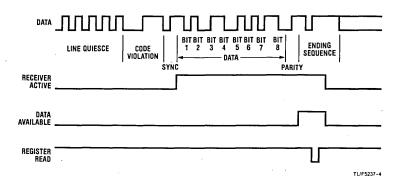


FIGURE 4A. Single Byte (8-Bit) Message

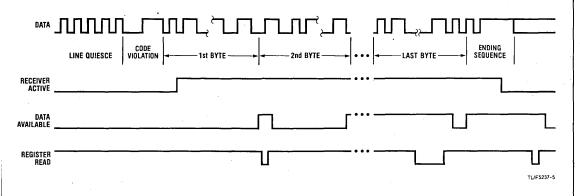


FIGURE 4B. Multi-Byte Message

Error Code Definition						
Data Bit DP8343	Error Type					
Bit 1	Data Overflow (Byte not removed from holding register when it and the input shift register are both full and new data is received)					
Bit 2	Parity Error (Odd parity detected)					
Bit 3	Transmit Check conditions (existence of errors on any or all of the following data bits: Bit 2, Bit 4, and Bit 5)					
Bit 4	An invalid ending sequence					
Bit 5	Loss of mid-bit transition detected at other than normal ending sequence time					
Bit 6	New starting sequence detected before data byte in holding register has been read					
Bit 7	Receiver disabled during receiver active mode					

#### **Serial Data**

### Data Clock

The Serial Data output is the serial data coming into the input shift register.

The Data Clock output is the clock to the input shift register.

### Message Format (Continued)

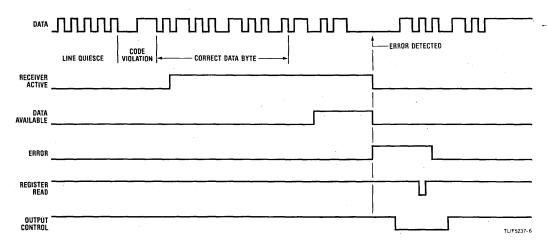


FIGURE 5. Message with Error

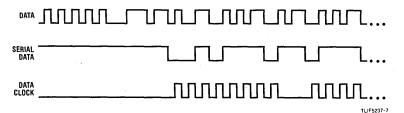


FIGURE 6. Data Clock and Serial Data

Units

٧

°C

### Absolute Maximum Ratings (Note 1)

# **Operating Conditions**

Supply Voltage, (V<sub>CC</sub>)

Ambient Temperature, TA

Min

4.75

0

Max

5.25

+70

Supply Voltage, V <sub>CC</sub>	7.0V
Input Voltage	5.5V
Output Voltage	5.25V
Storage Temperature Range	-65°C to 150°C
Lead Temperature (soldering, 10 seco	nds) 300°C

Maximum Power Dissipation\* at 25°C Cavity Package

Molded Package

2040 mW 2237 mW

### Electrical Characteristics (Notes 2, 3, and 5)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	Input High Level		2.0			٧
V <sub>IL</sub>	Input Low Level				0.8	V
V <sub>IH</sub> -V <sub>IL</sub>	Data Input Hysteresis (TTL, Pin 4)		0.2	0.4		V
V <sub>CLAMP</sub>	Input Clamp Voltage	$l_{IN} = -12 \text{mA}$		-0.8	-1.2	V
I <sub>IH</sub>	Logic "1" Input Current	$V_{CC} = 5.25V, V_{IN} = 5.25V$		2	40	μА
IIL	Logic "0" Input Current	$V_{CC} = 5.25V, V_{IN} = 0.5V$		-20	-250	μΑ
V <sub>OH</sub>	Logic "1" Output Voltage	$I_{OH} = -100 \mu A$	3.2	3.9		V
		$I_{OH} = -1  \text{mA}$	2.5	3.2		V
V <sub>OL</sub>	Logic "0" Output Voltage	I <sub>OL</sub> = 5 mA		0.35	0.5	٧
los	Output Short Circuit Current	V <sub>CC</sub> = 5V, V <sub>OUT</sub> = 0V (See Note 4)	-10	-20	-100	mA ,
loz	TRI-STATE® Output Current	$V_{CC} = 5.25V, V_{O} = 2.5V$	-40	1	+40	μΑ
	,	$V_{CC} = 5.25V, V_{O} = 0.5V$	-40	-5	+40	μΑ
A <sub>HYS</sub>	Amplifier Input Hysteresis		5	20	30	mV
Icc	Power Supply Current	V <sub>CC</sub> = 5.25V		160	250	mA

### Timing Characteristics (Notes 2, 6, 7, and 8)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
T <sub>D1</sub>	Output Data to Data Available Positive Edge		5	20	40	ns
T <sub>D2</sub>	Register Read Positive Edge to Data Available Negative Edge		1 10	25	45	ns
T <sub>D3</sub>	Error Positive Edge to Data Available Negative Edge	· · · · · · · · · · · · · · · · · · ·	10	30	50	ns
T <sub>D4</sub>	Error Positive Edge to Receiver Active Negative Edge		5	20	40	ns
T <sub>D5</sub>	Register Read Positive Edge to Error Negative Edge		20	45	75	ns
T <sub>D6</sub>	Delay from Output Control to Error Bits from Data Bits		5	20	50	ns
T <sub>D7</sub>	Delay from Output Control to Data Bits from Error Bits		5	20	50	ns
T <sub>D8</sub>	First Sync Bit Positive Edge to Receiver Active Positive Edge			3.5∗T +70		ns
T <sub>D9</sub>	Receiver Active Positive Edge to First Data Available Positive Edge			76 <b>∗</b> T		ns
T <sub>D10</sub>	Negative Edge of Ending Sequence to Receiver Active Negative Edge			11.5*T +50		ns
T <sub>D11</sub>	Data Control Set-up Multiplexer Time Prior to Receiving Data through Selected Input		40	30		ns
T <sub>D12</sub>	Serial Data Set-Up Prior to Data Clock Positive Edge			3*T		ns

<sup>\*</sup> Derate cavity package 13.6 mW/°C above 25°C; derate molded package 17.9 mW/°C above 25°C.

### Timing Characteristics (Continued) (Notes 2, 6, 7, and 8)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
T <sub>PW1</sub>	Register Read (Data) Pulse Width		40	30		. ns
T <sub>PW2</sub>	Register Read (Error) Pulse Width		40	30		ns
T <sub>PW3</sub>	Data Available Logic "0" State between Data Bytes		25	45	· ·	ns
T <sub>S</sub>	Output Control Set-up Time Prior to Register Read Negative Edge		0	-5		ns
T <sub>H</sub>	Output Control Hold Time After the Register Read Positive Edge		0	-5		ns
T <sub>ZE</sub>	Delay from Output Enable to Logic "1" or Logic "0" from High Impedance State	Load Circuit 2		25	35	ns
T <sub>EZ</sub>	Delay from Output Enable to High Imped- ance State from Logic "1" or Logic "0"	Load Circuit 2	-	25	35	ns
F <sub>MAX</sub>	Data Bit Frequency (Clock Input must be 8× the Data Bit Frequency)		DC		3.5	MBits/s

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min./max. limits apply across the 0°C to +70°C temperature range and the 4.75V to 5.25V power supply range. All typical values are for T<sub>A</sub> = 25°C and V<sub>CC</sub> = 5.0V.

Note 3: All currents into device pins are shown as positive; all currents out of device pins are shown as negative; all voltages are referenced to ground, unless otherwise specified. All values shown as max. or min. are so classified on absolute value basis.

Note 4: Only one output at a time should be shorted.

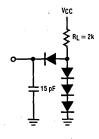
Note 5: Input characteristics do not apply to amplifier inputs (pins 2 & 3).

Note 6: Unless otherwise specified, all AC measurements are referenced to the 1.5V level of the input to the 1.5V level of the output and load circuit 1 is used.

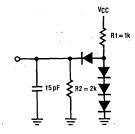
Note 7: AC tests are done with input pulses supplied by generators having the following characteristics:  $Z_{OUT} = 50\Omega$ ,  $T_f \le 5$ ns, and  $T_f \le 5$ ns.

Note 8: T = 1/ (clock input frequency), units for "T" should be ns.

### **Test Load Circuits**



**Load Circuit 1** 



Load Circuit 2

FIGURE 7.

TL/F5237-8

# **Timing Waveforms**

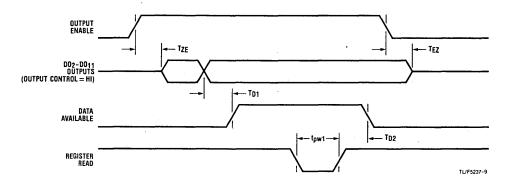


FIGURE 8. Data Sequence Timing

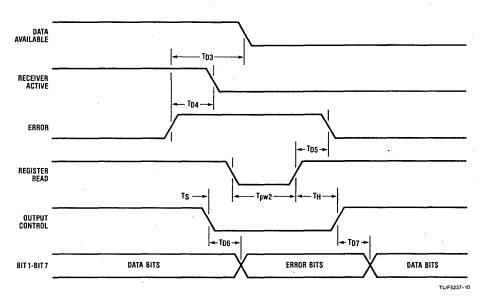


FIGURE 9. Error Sequence Timing

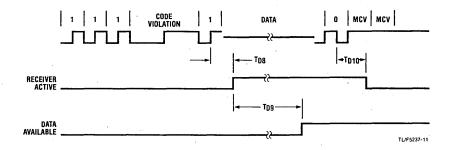


FIGURE 10. Message Timing

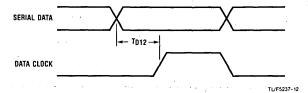


FIGURE 11. Data Clock and Serial Data Timing

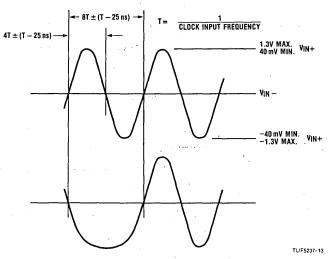


FIGURE 12. Data Waveform Constraints: Amplifier Inputs

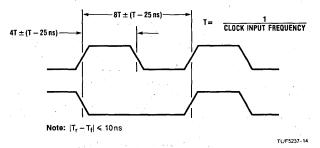


FIGURE 13. Data Waveform Constraints: Data Input (TTL)

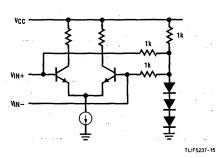
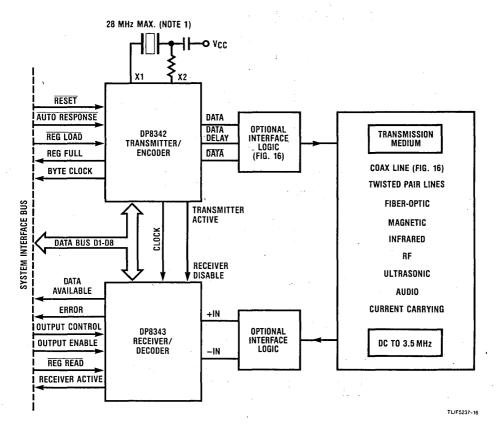


FIGURE 14. Equivalent Circuit for DP8343 Input Amplifier

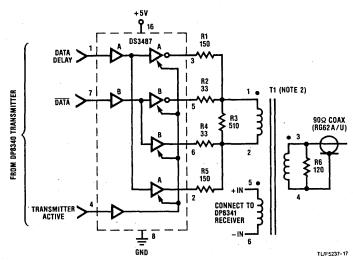
### **Typical Applications**



Note 1: Crystal manufacturer Midland Ross Corp., NEL Unit Part No. NE-18A @ 28MHz

FIGURE 15.

### **Typical Applications (Continued)**



Notes: 1) Resistance values are in ohms, ±5%, 1/4 W.

2) T1 is a 1:1:1 pulse transformer, L<sub>MIN</sub> = 500 µH for 18 MHz system clock. Pulse Engineering Part No. 5762 Technitrol Part No. 11LHA or equivalent transformers.

FIGURE 16. Interface Logic for A Coax Transmission Line

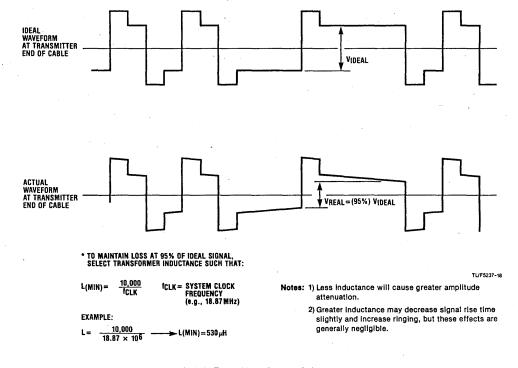


FIGURE 17. Transformer Selection



## Section 10 Disk Support



DEVICE	DESCRIPTION	PAGE NUMBER
AN-334	LSI Components for Winchester Disk Drives and Controllers	10-3
DP8460	Data Separator	10-10
DP8464	Disk Pulse Detector	10-31
DP8466	Disk Data Controller	10-34



# LSI Components for Winchester Disk Drives and Controllers

National Semiconductor Application Note 334 Mike Evans John Payne Tim Stout March 1983



#### INTRODUCTION

Designing an LSI solution for disk system data path electronics requires careful examination of the total disk market place. The objective is to have a high performance solution able to handle state-of-the-art, 14-inch drives while still being reasonably priced for the lower performance, highly cost-sensitive 5 1/4-inch market. The OEM Winchester disk market consists of three main device types: 14-inch, 8-inch and 5 1/4-inch. OEM supplied 14-inch drives range from capacities of 40 megabytes upwards to 1 gigabyte with data rates of 10-24 megabits/second and access times of 25 ms. The 8-inch Winchester drives evolved from scaling of the 14-inch drives and are suitable devices for minicomputer environments. Storage capacities vary from 16 megabytes to 200 megabytes with typical data rates of 7-9 megabits/second and typical access times of 30 ms. The 5 1/4-inch Winchester drive offers a high performance, high capacity version of the established 5 1/4-inch floppy disk. It is thus ideally suited to packaging in microcomputer-based systems. Initially, 5 1/4-inch drives offered 6 megabytes of storage with typical access times of 170 ms. Recently, devices have been announced with storage capacities of over 100 megabytes and access time of 30 ms. Data rates are typically 5 Mbits/ second, but will increase.

#### PERFORMANCE/STANDARDS SET DESIGN AIMS

The rapid evolution of Winchester drives has pushed storage capacities, data rates and access times to the limit. The DP8460 series hard disk chip set has been designed to handle data rates as high as 25 megabits/ second to interface with the fastest drives now available. The chip set uses the latest bipolar and CMOS processing techniques as shown in Figure 1.

The use of high density run-length-limited codes is well established in the 14-inch market and will migrate to the 8-inch and 5 1/4-inch drives. A further consideration of the design was the ability to work with such codes. Similarly, as storage densities increase, the necessity for ECC (error checking and correcting) electronics becomes apparent. Specific codes have yet to become standard since some in use today are considered inadequate for the future. The hard disk chip set design was required to anticipate such future developments. Furthermore, the design and functional partitioning had to take into account existing standards such as SMD and ANSI X3.101 and yet allow flexibility in areas where standards are still emerging. Finally, the introduction of removable media cartridges places increasing emphasis on programmable format.

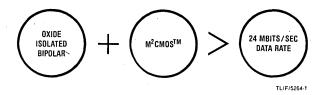


FIGURE 1. Two New Processes Provide Fast Data Rate Capability

M<sup>2</sup>CMOS<sup>TM</sup> is a trademark of National Semiconductor Corp.

#### **FUNCTIONS COMMON TO ALL DISK SYSTEMS**

There are certain functions which all disk systems typically perform (*Figure 2*). As one looks at the data path of a disk system during a read operation, following it from the recording head to the host, there emerge eight well defined functions that are common to all disk drives.

These are:

- 1. Select the desired head and preamplify the signal from it.
- Convert the data signal from an analog waveform into a sequence of digital pulses.
- Generate a clock and synchronized data from the digital pulse train using phase-locked-loop techniques.
- 4. Decode the synchronized data using the clock.
- Deserialize the data into byte-wide blocks and bytealign.
- Identify the desired sector and strip off synchronization information, addressing information, and error check information.
- 7. Buffer the valid data from the desired sector.
- 8. Transfer the data into the hosts's main storage.

Six similar functions are required for writing the data:

- 1. Transfer the data out of the host's main storage.
- 2. Buffer the data.
- Identify the desired sector, then append synchronization and error checking fields to the data field.
- 4. Serialize the data.
- 5. Encode the data.
- Select the correct recording head and drive it with the encoded data signal.

A disk system is typically separated into two subsystems, the drive and the controller. However, there is no single definition as to which functions are performed in which place, the major disk-to-controller interfaces make the division in different places.

In the floppy extension interface (ST506), the drive performs the functions related to head selection, driving, preamplification, and the analog-to-digital conversion. Everything else is done in the controller. For the SMD and ANSI X3.101 interfaces the drive also performs read clock generation, data decoding, and data encoding. Finally, with the intelligent disk interface, all of the functions are performed by the drive except DMA, which is done by the controller.

The DP8460 series will work with all of the interfaces discussed above. The chips implementing the various functions are placed in the drive or the controller depending upon the particular interface used. The first chips in the set, the pulse detector, data separator, and disk data controller perform all of the functions discussed above with the exception of head operations.

The DP8464 pulse detector converts the analog signal from the head preamplifier into digital pulses. The DP8460 data separator performs read clock generation utilizing an internal phase-locked-loop and data signal decoding. The DP8466 disk data controller performs the remaining functions.

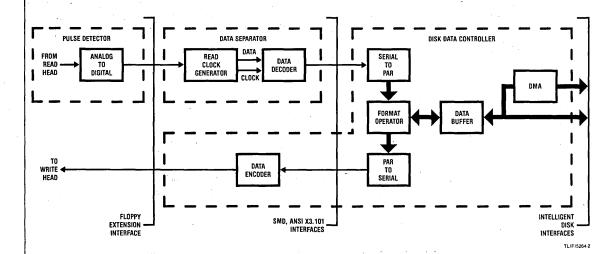


FIGURE 2. Disk Data Path Functions

#### **DP8464 PULSE DETECTOR**

The pulse detector receives the analog signal from the read/write head amplifier and converts the peaks to digital pulses. It is always situated in the disk drive. The primary purpose of the pulse detector is to convert the analog signal received from the recording head into a sequence of digital pulses that can be decoded by the data separator (Figure 3). Each flux reversal of the recording media represents a coded "1"; the absence of a reversal in a given window time represents a coded "0".

The pulse detector sees flux reversals as signal peaks from the recording head, and produces digital output

pulses coinciding with the position of the incoming signal peaks.

Figure 4a is a plot of relative pulse amplitude versus bits per inch (or recording density). As the recording density increases, bit interaction causes the signal amplitude to decrease.

Pulse shapes as received by the pulse detector are shown in *Figure 4b*. Regions 1 and 2, the ones predominantly associated with disk drives, are characterized by the analog signal returning to the baseline between pulses.

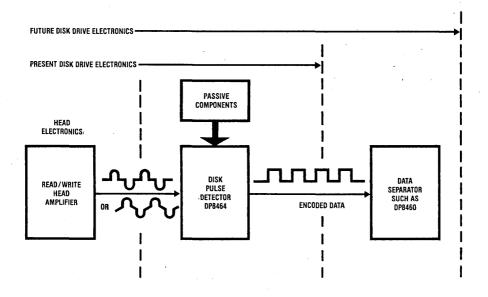


FIGURE 3. Pulse Detector in a Disk System

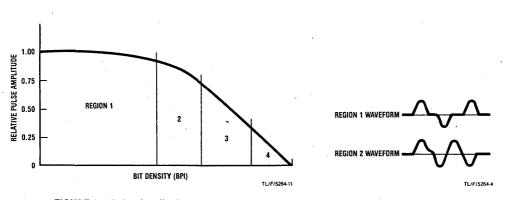


FIGURE 4a. Pulse Amplitude vs Bit Density

FIGURE 4b. Typical Waveforms

TL/F/5264-3

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Peak detection is complicated by the susceptibility of the circuitry to noise peaks during this period. The trickiest part of the pulse detector design is to distinguish between signal peaks and noise peaks.

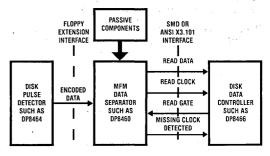
Region 1 is characterized by minimal amplitude distortion with a prolonged return to the baseline. Drives using thin film media or thin film head technology or run-length-limited codes characteristically produce such pulses. The region 1 detector functions by enabling the differentiator from a threshold comparator (*Figure 5*). Only if the signal is greater than a preset threshold will an output pulse be enabled. Since noise peaks are characteristically of low amplitude, this approach effectively eliminates output pulses due to noise.

Average signal strengths from the recording head will vary from track to track and even along the same track. Hence, use of threshold comparison and signal processing mandates automatic gain control (AGC) circuitry to maintain a constant output from the wideband amplifier.

Region 2 is characterized by some amplitude distortion and a tendency for the signal to return to the baseline. Drives using conventional ferrite heads with MFM typically produce such pulses. The pulse detector will work with most drives operating in regions 1 and 2.

#### **DATA SEPARATOR**

The DP8460 data separator performs the two basic functions of read clock generation (using an internal phase-locked-loop) and MFM decoding (for MFM systems). It is usable with all of the interfaces discussed in this article. It receives encoded data from a pulse detector and outputs data and clock signals to the controller (Figure 6). A block diagram of the chip is shown in Figure 7.



\*Soft-sectored disks only

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FIGURE 6. Data Separator in a Hard Disk System

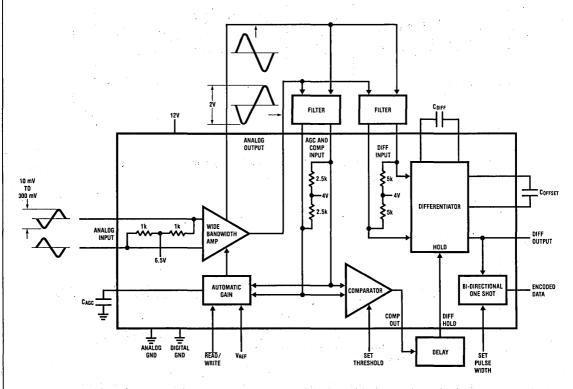
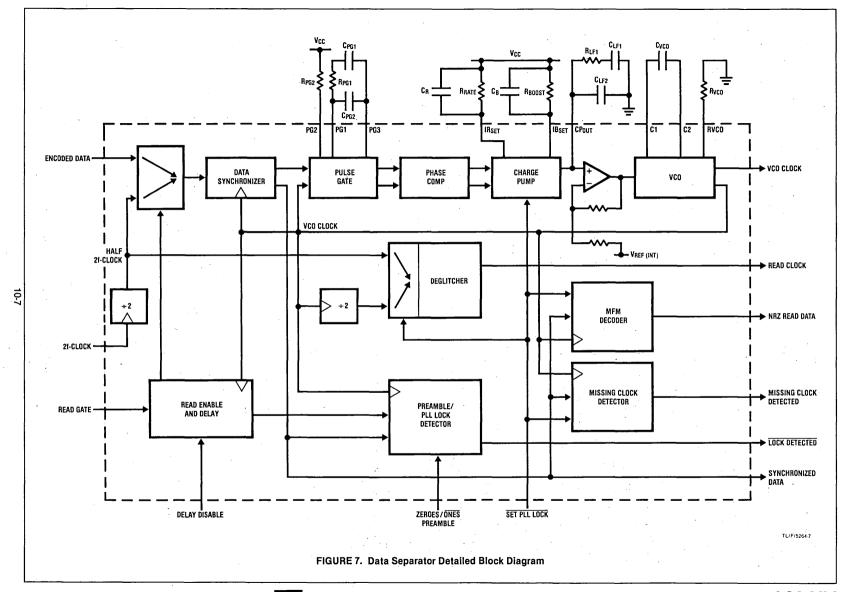


FIGURE 5. Pulse Detector Block Diagram

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The upper half of the block diagram is the phase-locked-loop which is the heart of the chip. The PLL may be used with disks employing MFM or run-length-limited codes. A serial data output is derived from the incoming raw data that is synchronized to the clock generated by the PLL. The synchronized data and clock pair then connect to an external data decoder for run-length-limited codes. When MFM encoding is used, the output connects internally to the MFM decoder.

The PLL features two user-selectable tracking rates. A high tracking rate is used while the PLL is locking onto the data stream, but once lock-on is achieved, a more stable and slower tracking rate is used. This offers an extremely quick lock-on time of less than two bytes, while allowing reliable operation by removing bit shift distortions when reading the actual data. The tracking rate switches when the external SET PLL LOCK signal goes active. When the chip is not read-enabled, the PLL tracks an external clock source. In a servo system, this is typically the servo clock, while stepper motor drives use a crystal. This allows the PLL to be at frequency when data decoding begins.

Internal to the phase-locked-loop is a clock gate circuit which delays the data signal by an amount equal to half of the window. No external delay lines are required. The delay is guaranteed to be within a specified narrow time slot for all internal sources of error combined.

To generate the read clock, a clock multiplexer and deglitcher are used. The ANSI X3.101 specification calls for only one clock between the drive and controller, which is a combined read clock/servo clock signal. The SMD specification, on the other hand, specifies both clocks are to be on the interface simultaneously. The chip follows the ANSI specification so that it can work in both systems.

When SET PLL LOCK goes active, the READ CLOCK output switches from external clock to the PLL clock. The switch back takes place when the READ GATE signal goes inactive. The deglitcher ensures that no short clock periods are ever sent to the controller as a result of the switch between the two clocks.

The other portion of the chip is a data decoder that is used with systems using the MFM data code. Before lock-on the MFM decoder assumes that every incoming pulse is a clock pulse and not MFM data. When SET PLL LOCK goes active, the phase pattern between clock pulses and data pulses is frozen to allow decoding of the data. The output of this section is sent to the controller as NRZ READ DATA along with the synchronous READ CLOCK.

The missing clock detector monitors the incoming data pattern for an MFM missing clock violation. If there is an incoming address mark, and a missing clock is detected, the chip activates the signal MISSING CLOCK DETECTED.

#### **DISK DATA CONTROLLER**

The DP8466 disk data controller is designed to control the data transfer between the disk drive and the system as shown in *Figure 8*. All other functions are left to a microcontroller or microprocessor. The DDC interfaces to the data separator, on one side, and the system bus or an intelligent disk interface, on the other side. The primary data path functions are to sequence the format field, identify the desired sector, serialize memory data when writing to disk, and to deserialize and byte-align the disk data. Other data path functions performed are data buffering and DMA handling. See *Figure 9* for a block diagram of the chip.

It is inadequate to store data on the disk media directly as received from the host. Various extra fields are needed. The external PLL needs a preamble field in order to achieve lock-on. The deserializer needs a synch field to distinguish the end of the preamble to establish byte boundaries within the serial data stream. Address fields, called headers, are needed to identify and locate specific blocks of data. Error checking and correcting fields are typically appended to the data, as well as various types of postambles and gaps.

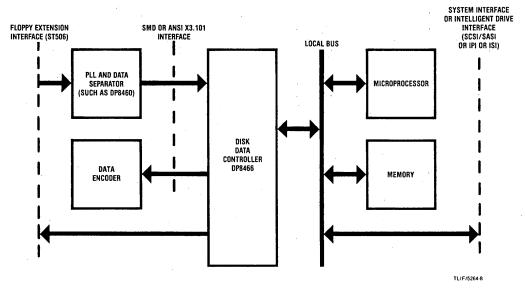


FIGURE 8. Disk Data Controller in a Disk System

TL/F/5264-10

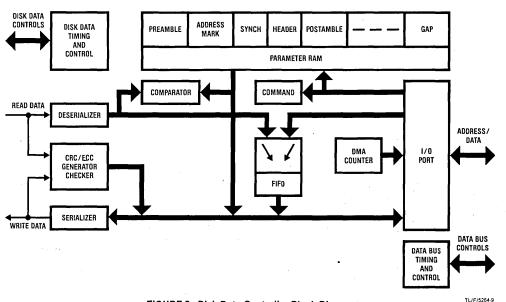


FIGURE 9. Disk Data Controller Block Diagram

FORMAT 1				_											
PREAMBLE	A.M.	SYNCH	HDR	CRC/ECC	EXT ECC	POSTAMBLE	PREAM	BLE	A.M.	SYNCH	DATA	CRC/ECC	EXT ECC	POSTAMBLE	GAP
FORMAT II															
PREAMBLE	SYNC	HDR	CRC/EC	C EXT EC	C POSTA	MBLE PREA	MBLE	SYNCH	DATA	CRC/	ECC	EXT ECC	POSTAMBLE	GAP	
FORMAT III															
PREAMBLE	SYNC	H HDR	CRC/EC	CC DATA	CRC/ECC	EXT ECC	POSTA	MBLE	GAP						

FIGURE 10. Typical Disk Formats

The particular sequence and combination of fields used in storing information on the disk is called the format. There is no standard format which is used in all disk drives, but three popular formats are shown in *Figure 10*. To meet all the different needs of these drives, the chip is externally programmable. The user chooses his own preamble, synch pattern, address mark, postamble and gap, and the order of the format. This is usually performed only once, at initialization. During normal operations such as reading to, or writing from the disk, header information is written to the chip from the microprocessor, along with the mode of operation to be performed such as single or multi-sector, read, or write. Information in the status register or the error register may be accessed.

The serializer converts the parallel data from memory into a serial bitstream and outputs it as NRZ data coincident with the WRITE CLOCK, to interface direct to the SMD or ANSI interfaces. The DDC may also be configured to output MFM encoded data to interface easily to the floppy extension (ST506) interface. The deserializer converts the serial bitstream into byte-wide data for memory. The deserializer features a comparator which is not only used to perform the initial byte-boundary synchronization but is also used in identifying header address.

An internal 32-byte (16-word) FIFO buffers memory data transfers. This FIFO is sufficiently deep to allow extensive microprocessor usage during transfer operations without causing overruns. The chip can be set to transfer data 8 bits or 16 bits at a time. Direct memory access (DMA) capabilities are also included on-chip. A counter provides a 16-bit address field which can be strobed out of the I/O bus prior to valid data. DMA handshake and control signals are provided. This eliminates the need for an external DMA controller chip, and allows faster memory transfers.

Cyclic redundancy check (CRC) or ECC calculations are made on-chip and appended to the data stream when writing, or checked with the CRC/ECC appendage when reading. When the on-chip CRC/ECC codes are undesirable, external circuitry may be used. The disk data controller has two control pins for communication with such circuitry.

Besides the standard features discussed above, the chip has a number of special features. A unique interrupt, called HFASM, notifies the microprocessor that the header failed but the sector numbered matched; this is usually a serious condition requiring immediate attention. If this condition occurs, the last header field read is stored internally and is accessible to the microprocessor. Sector interlocking is available for special microprocessor format sequencing. In multiple sector operations, checkpoint interrupts to the microprocessor are available.

## Disk Support

## **DP8460 Data Separator**

### **General Description**

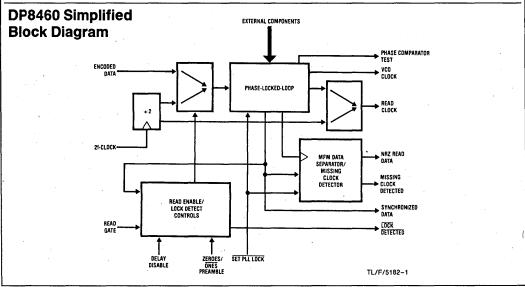
The DP8460 Data Separator is designed for application in disk drive memory systems, and depending on system requirements, may be located either in the drive or in the controller. It receives digital pulses from a pulse detector circuit (such as the DP8464 Disk Pulse Detector), if the DP8460 is situated in the drive, or from the Floppy Extension Interface if it is situated in the controller. After locking on to the frequency of these input pulses, it separates them into synchronized data and clock signals. If the input pulses are MFM encoded data, the data is made available as decoded NRZ data to be deserialized directly by a controller (such as the DP8466 Disk Data Controller). If a run-length-limited code is used, the synchronized data output is available to allow external circuitry to perform the data decoding function. All of the digital input and output signals are TTL compatible and only a single +5V supply is required. The chip is housed in a standard narrow 24-pin dual-in-line package (DIP) and is fabricated using Advanced Schottky bipolar analog and digital circuitry. This high speed I.C. process allows the chip to work with data rates up to 25Mbit/sec. There are three versions of the chip, each having a different decode window error specification. All three versions (-2, -3, -4) will operate from 2 to 25Mbit/sec, with respectively increasing window errors, as specified in the Electrical Characteristics Table.

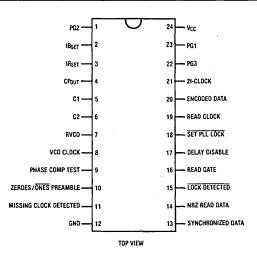
The DP8460 features a phase-lock-loop (PLL) consisting of a pulse gate, phase comparator, charge pump, buffering amplifier, and voltage-controlled-oscillator (VCO). Pins are provided for the user to select the values of the external filtering components required for the pulse gate and amplifier, the frequency setting components required for the VCO, and two current setting resistors for the charge pump. The

DP8460 has been designed to lock on to the incoming preamble data pattern within the first two bytes, using a high rate of charge pump current. Once lock-on has been achieved, the charge pump switches to a lower rate (both rates being determined by the external resistors) to maintain stability for the remainder of the read operation. At this time the READ CLOCK output switches, without glitching, from half the 2f-CLOCK frequency to half the VCO CLOCK frequency. After lock-on, with soft sectored disks, the MISS-ING CLOCK DETECTED output indicates when a missing clock in an address mark field occurs so the controller can align byte boundaries to begin deserialization of the incoming data.

#### **Features**

- Operates at data rates up to 25Mbit/sec
- Separates MFM data into read clock and serial NRZ data
- 4 byte preamble-lock indication capability
- Preamble recognition of MFM encoded "0"s or "1"s
- User-determined PLL loop filter network
- PLL charge pump has two user-determined tracking rates
- External control of track rate switchover
- No glitch on READ CLOCK at switchover
- Synchronized data provided as an output (for RLL codes)
- ORed phase comparator outputs for monitoring bit-shift
- Missing clock detected for soft sectored disks
- Less than ½W power consumption
- Standard narrow 24-pin DIP
- Single +5V supply





#### **PIN DEFINITIONS:**

Power Supply

24 Vcc +5V ±5%

12 Ground

#### TTL Level Logic Inputs

- 16 READ GATE: This is an active high input signal that sets the DP8460 Data Separator into the Read Mode.
- 17 DELAY DISABLE: This input determines the delay from READ GATE going high to the time the DP8460 enters the Read Mode. If DELAY DISABLE is set high, this delay is within one cycle of the 2f-CLOCK signal. If DELAY DISABLE is set low, the delay is thirty two cycles of the 2f-CLOCK, as shown in Figure 1.
- 18 SET PLL LOCK: This input allows the user to determine when the on-chip PLL will go into the low track rate. A high level at this input results in the PLL being in the high track rate. If this input is connected to the LOCK DETECTED output, the PLL will go into the low track rate mode immediately after lock is detected.
- 10 ZEROES/ONES PREAMBLE: A high level on this input enables the circuit to recognize an All Zeros data preamble. A low level results in the recognition of an All Ones data preamble.
- 20 ENCODED DATA: This input is connected to the output of the head amplifier/pulse-detecting network located in the disk drive. Each positive edge of the ENCODED DATA waveform identifies a change of flux on the disk. In the case of MFM encoded data, the input will be raw MFM.
- 21 2f-CLOCK: This is a system clock input, which is either a signal generated from the servo track (for systems utilizing servo tracks), or a signal buffered from a crystal.

#### TTL Level Logic Outputs

- 8 VCO CLOCK: This is the output of the on-chip VCO, transmitted from an Advanced Schottky-TTL buffer. It is synchronized to the MFM data output and, if needed, it can be used as the 2f-CLOCK for encoding MFM when writing to the disk.
- 15 LOCK DETECTED: This output goes active low only after both PLL Lock has occurred and the preamble pattern has been recognized. It remains low until READ GATE goes inactive.

- 14 NRZ READ DATA: This is the NRZ decoded data output, whose leading edges coincide with the trailing edge of READ CLOCK.
- 13 SYNCHRONIZED DATA: This output is the same encoded data that is input to the chip, but is synchronous with the negative edge of the VCO CLOCK.
- 11 MISSING CLOCK DETECTED: When a missing clock is detected, this output will be a single pulse (of width equal to one cycle of READ CLOCK) occurring as shown in *Figure 2*.
- 19 READ CLOCK: This is half VCO CLOCK frequency during read mode after PLL Lock; it is half 2f-CLOCK frequency at all other times. A deglitcher is utilized to ensure that no short clock periods occur during either switchover.
- 9 PHASE COMP TEST: This output is the logical "OR" of the Phase Comparator outputs, and may be used for the testing of the disk media.

#### Analog Signals

- 23, 22, PG1, PG3: The external capacitors and resistor of the Pulse Gate filter are connected to these pins.
- 1 PG2: This is the Pulse Gate current supply.
- 3 IRSET: The current into the rate set pin (VBE/R<sub>Rate</sub>) is half the charge pump output current for the slow tracking rate.
- 2 IBSET: The current into the boost set pin ( $V_{BE}/R_{Boost}$ ) is half the amount by which the charge pump current is increased for the high tracking rate. ( $I_{HIRATE} = I_{RATE}$  Set +  $I_{BOOST}$  Set).
- 4 CPOUT: CHARGE PUMP OUT/BUFFER AMP IN is available for connection of external filter components, for the phase-lock-loop. In addition to being the charge pump output node, this pin is also the noninverting input to the opamp of the Buffer Amplifier.
- 7 RVCO: The current into this pin determines the operating currents within the VCO.
- 5, 6 VCO C1, C2: An external capacitor connected across these pins sets the nominal VCO frequency.

## **Absolute Maximum Ratings**

Supply Voltage 7V
TTL Inputs 7V
Output Voltages 7V
Input Current (CPOUT, IRSET, IBSET, RVCO) 2mA
Storage Temperature -65°C to 150°C

## **Operating Conditions**

Symbol	Parameter	Conditions	Min	Тур	Max	Units
Vcc	Supply Voltage		4.75	5.00	5.25	V
$T_A$	Ambient Temperature		0	25	70	°C
ЮН	High Logic Level Output Current	V <sub>CO</sub> Clock Others			-2000 -400	μΑ
lor	Low Logic Level Output Current	V <sub>CO</sub> Clock Others			20 8	mA
fDATA	Input Data Rate		2.0		25	Mbit/sec
twck	Width of 2f-CLOCK, High or Low		10	]	[	ns
twpD	Width of ENCODED DATA Pulse, High or Low (Note 2)		0.25t			ns
V <sub>IH</sub>	High Logic Level Input Voltage		2			V
$V_{IL}$	Low Logic Level Input Voltage	`			0.8	l v

## DC Electrical Characteristics Over Recommended Operating Temperature Range

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min., I <sub>I</sub> = -18mA			-1.5	V
V <sub>OH</sub>	High Level Output Voltage	V <sub>CC</sub> = Min., I <sub>OH</sub> = Max.	V <sub>CC</sub> -2V	V <sub>CC</sub> -1.6V		V
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min., I <sub>OL</sub> = Max.			0.5	V
l <sub>iH</sub>	High Level Input Current	V <sub>CC</sub> = Max., V <sub>I</sub> = 2.7V			20	μА
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max., V <sub>I</sub> = 0.4V			-200	μА
lo	Output Drive Current	$V_{CC} = Max., V_O = 2.125V^1$	-30		-110	mA
Icc	Supply Current	V <sub>CC</sub> = Max.			100	mA
Гоит	Charge Pump Output Current	IRSET = VBE/RRATE IBSET = VBE/RBOOST	-10% -10%	2×I <sub>RSET</sub> 2×(I <sub>RSET</sub> +I <sub>BSET</sub> )	+10% +10%	mA

<sup>1.</sup> This value has been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.

<sup>2.</sup> t is defined as the period of the encoded data

## $\textbf{AC Electrical Characteristics} \ \ \text{Over Recommended V}_{\text{CC}} \ \text{and Operating Temperature Range}.$

(All Parts unless stated otherwise)

 $(t_R = t_F = 2.0 \text{ns}, V_{IH} = 3.0 \text{V}, V_{IL} = 0 \text{V})$ 

Symbol	Parameter	Min	Тур	Max	Units
<sup>t</sup> READ	Positive READ CLOCK transitions from READ GATE set active until PLL Lock sequence begins (DELAY DISABLE low)		16	17	_
<sup>†</sup> READ	Positive READ CLOCK transitions from READ GATE set active until PLL Lock sequence begins (DELAY DISABLE high)		1	1	_
<sup>†</sup> DECODE NRZ	Number of READ CLOCK cycles required to output each decoded MFM data bit <sup>4</sup>	_	2	3.	T-clock
<sup>†</sup> TRANSMIT MFM	Positive READ CLOCK transitions required to transmit input MFM to output	1	2	3	
<sup>†</sup> READ ABORT	Number of READ CLOCK cycles after READ GATE set low to read operation abort			2	T-clock
twindow	Variance of center of decode window from nominal <sup>7</sup> DP8460-2 DP8460-3 DP8460-4			2+0.6%τ 3+0.8%τ 4+1.0%τ	ns
ΦLINEARITY	Phase range for charge pump output linearity <sup>2</sup>	-π		+π	Radians
K <sub>1</sub>	Phase Comparator — Charge Pump gain constant <sup>5</sup>		V <sub>BE</sub> πR		Amps/rad
VCONTROL	Charge pump output voltage swing from nominal		±100		mV
K <sub>VCO</sub> (=A×K <sub>2</sub> )	VCO gain constant (ω <sub>VCO</sub> = VCO center frequency in rad/s) <sup>6</sup>		1.6ω <sub>C</sub>	1.8ω <sub>C</sub>	rad/sec. V
			V <sub>BE</sub>	V <sub>BE</sub>	144/300. V
fvco	VCO center frequency variation over temperature and V <sub>CC</sub>	-5		+5	%
fMAX VCO	VCO maximum frequency	70			MHz
<sup>t</sup> HOLD	Time READ CLOCK is held low during changeover after lock detection has occurred <sup>3</sup>		-	11/2	T-clock
<sup>t</sup> MFMSKEW	Output skew between VCO clock and Synchronized Data				ns
tNRZSKEW	Output skew between READ CLOCK, NRZ READ DATA and MISSING CLOCK DETECTED			-	ns

<sup>1.</sup> A sample calculation of frequency variation vs. control voltage:  $V_{\mbox{\scriptsize IN}}$  =  $\pm 0.2 \mbox{\scriptsize V}_{\mbox{\scriptsize I}}$ 

$$c_{O} = \frac{\omega_{OUT}}{V_{IN}} = \frac{0.4 \,\omega_{C}}{0.2V} = \frac{2.0 \,\omega_{C}}{V} \quad \frac{\text{(rad/sec}}{\text{(volt)}}$$

$$I_{SET} = \frac{V_{BE}}{R_{SET}}$$

<sup>2.</sup>  $-\pi$  to  $+\pi$  with respect to 2f VCO CLOCK

<sup>3.</sup> T-clock is defined as the time required for one period of the READ CLOCK to occur.

<sup>4.</sup> This number remains fixed after PLL Lock occurs.

<sup>5.</sup> With respect to VCO CLOCK; I<sub>PUMP OUT</sub> = 2 I<sub>SET</sub>

<sup>6.</sup> Although specified as the VCO gain constant, this is the gain from the Buffer Amplifier input to the VCO output.

 $<sup>{}^{\</sup>text{-}}$  7. au is defined as the period of the incoming data stream

СВ

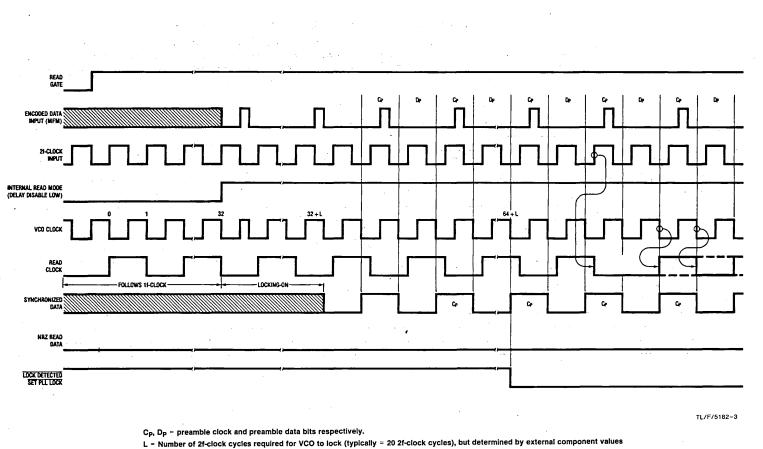
IBOOST Bypass Capacitor

external Component Selection (All Parts)						
Symbol	Component	Min	Тур	Max	Unit	
R <sub>VCO</sub>	VCO Frequency Setting Resistor	990		1010	Ω	
C <sub>VCO</sub>	VCO Frequency Setting Capacitor	15	**		pF	
R <sub>LF</sub>	Loop Filter Resistor	TBD		TBD	Ω	
C <sub>LF1</sub>	Loop Filter Capacitor 1	20		TBD	pF	
C <sub>LF2</sub>	Loop Filter Capacitor 2	20		TBD	pF	
R <sub>RATE</sub>	Charge Pump I <sub>RATE</sub> Set Resistor	1.2		6.5	kΩ	
R <sub>BOOST</sub>	Charge Pump (High Rate) IBOOST Resistor	0.4		∞	kΩ	
R <sub>PG2</sub>	Delay Time Setting Resistor	0		150	kΩ	
R <sub>PG1</sub>	Pulse Gate Resistor	TBD		TBD	kΩ	
C <sub>PG1</sub>	Pulse Gate Capacitor C1	20		TBD	pF	
C <sub>PG2</sub>	Pulse Gate Capacitor C2	20		TBD	pF	
CR	I <sub>RATE</sub> Bypass Capacitor	1000			pF	

1000

рF





At 32 + L, VCO has just locked.

At 64 + L, circuit has confirmed lock (has been in lock for 16 MFM clock bits). This sequence shows the MFM preamble pattern.

FIGURE 1. Lock-on Sequence Waveform Diagram

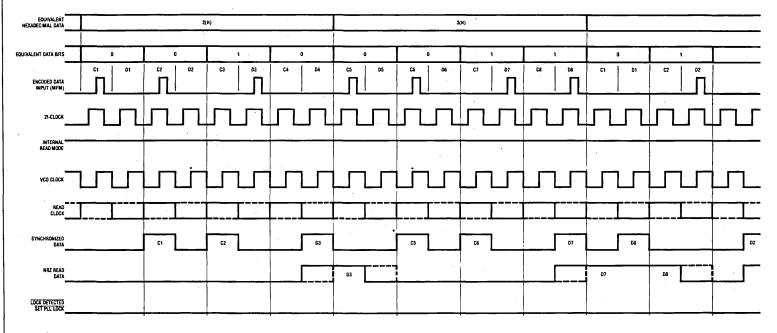


- READ CLOCK and NRZ READ DATA may be delayed by one VCO clock period depending on the phase of the internal clock at activation of READ GATE input.
- MISSING CLOCK DETECTED is one READ CLOCK period ahead of the chip issuing D8 on the NRZ READ DATA output when READ CLOCK is delayed by one VCO clock period
- MISSING CLOCK DETECTED is synchronous with the chip issuing D8 on the NRZ READ DATA Output when READ CLOCK is not delayed

10-16

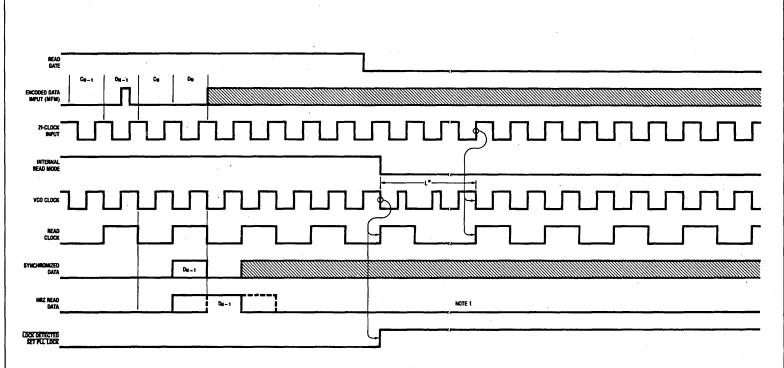
FIGURE 2. Missing Clock Detection Waveform Diagram





• READ CLOCK and NRZ READ DATA may be delayed by one VCO clock period with respect to Synchronized Data depending on the phase of the internal clock at activation of READ GATE input.

FIGURE 3. Locked-on Waveform Diagram



• L Indicates the number of cycles required for the VCO to lock to the 2f-CLOCK

NOTE 1: READ GATE going low will always result in NRZ READ DATA going low regardless of the state of the last bit

FIGURE 4. Lock-Ending Sequence Waveform Diagram

#### **CIRCUIT OPERATION**

When the READ GATE input goes high, the DP8460 Data Separator enters the read mode after a period determined by the state of the DELAY DISABLE pin. This may be either one or thirty two 2f-CLOCK cycles. Referring to Figure 1, once in the read mode, the phase-locked-loop reference signal is switched from 2f-CLOCK input to the ENCODED DATA input. The PLL, initially in the high-tracking rate mode, then attempts to lock onto the incoming encoded data stream. By careful selection of the loop filter components, this can be within 2 bytes. Preamble pattern recognition then can begin. As soon as two bytes of the selected preamble are detected, (the selection is determined by the ZE-ROES/ONES PREAMBLE pin) the LOCK DETECTED output goes low. In a typical MFM disk drive application, the LOCK DETECTED output is directly connected to the SET PLL LOCK input. With this connection, track rate selection, clock output switchover, and data output enabling will occur after four consecutive preamble bytes have been fed into the chip, from the time the read mode began.

A low level on the SET PLL LOCK causes the PLL Charge Pump to switch from the high to low tracking rate. At the same time the source of the READ CLOCK signal is switched from half the frequency of the 2f-CLOCK to half the VCO clock. The MFM decoder also becomes enabled and begins to output decoded NRZ data. If the preamble is being decoded, and it is a zeroes data preamble, the NRZ READ DATA output will remain low until the end of the preamble. It will then output NRZ data some 2f-CLOCK periods after the preamble field has ended, as shown in Figures 2 and 3

Figure 4 shows the sequence when READ GATE goes low, signifying the end of a read operation. The PLL reference signal is switched back to half the 2f-CLOCK and the LOCK DETECTED output (and therefore the SET PLL LOCK input) goes high. The PLL then returns to the high tracking rate, and the output signals return to their initial conditions.

#### CIRCUIT DESCRIPTION

- 1. Read Enable and Delay: If the DELAY DISABLE input is connected low, then thirty two 2f-CLOCK cycles after READ GATE goes active, the DPB460 will go into the read mode. If the DELAY DISABLE input is connected high, the chip will go into the read mode one 2f-CLOCK cycle after READ GATE goes active. This feature allows the user to choose the time at which the PLL Lock Sequence begins and thus accommodates systems with short preambles.
- 2. Pulse Gate, including Input Multiplexer and Data Synchronizer: The Input Multiplexer selects the input to the phase-lock-loop. While the chip is in the bypassed mode, the PLL is locked on half the 2f-CLOCK frequency, but in the read mode, the Input Multiplexer switches to the ENCODED DATA signal. The VCO CLOCK then begins to synchronize with the ENCODED DATA signal. The Pulse Gate allows a reference signal from the VCO into the Phase Comparator only when a ENCODED DATA bit is valid. The Pulse Gate utilizes a scheme which delays the incoming data by one-half the period of the 2f-CLOCK. This optimizes the position of the decode window and allows input jitter up to ± half the 2f-CLOCK period, assuming no error in the decode window position. The decode window error can be determined from the specification in the Electrical Characteristics Table.

- Phase Comparator: The Phase Comparator receives its inputs from the Pulse Gate, and is edge-triggered from these inputs to provide charge-up and charge-down outputs.
- 4. Charge Pump: The high speed charge pump consists of a switchable constant current source and sink. The charge pump constant current is set by connecting external resistors to Vcc from the charge current rate set (IRSET) and current boost set (IBSET) pins. Before lock is indicated, the PLL is in the fast tracking rate and both resistors determine the current. In the slow tracking rate after lock-on, only the IRSET resistor determines the charge pump current. The output of the charge pump feeds into external filter components and the Buffer Amplifier.
- 5. Buffer Amplifier: The input of the Buffer Amplifier is internally connected to the charge pump's constant current source/sink output as well as the external Loop Filter components. The Buffer Amplifier is configured as a high input impedance amplifier which allows for the connection of external PLL filter components to the Charge Pump output pin CPOUT. The output of the Buffer Amplifier is internally connected to the VCO control input.
- 6. VCO: The Voltage-Controlled-Oscillator requires a resistor from the RVCO pin to ground and a capacitor between pins C1 and C2, to set the center frequency. The VCO frequency can be varied from nominal by approximately  $\pm 20\%$ , as determined by its control input voltage.
- 7. PLL Lock-on/Preamble Pattern Detector: To recognize preamble, the preamble pattern from the disk must consist exclusively of either data bit zeroes (encoded into ..10.. MFM clock pulses) when the ZEROES/ONES PREAMBLE pin is set high, or data bit ones (encoded into ..01.. MFM clock pulses) when set low. The preamble pattern must be long enough to allow the PLL to lock, and subsequently for the Preamble Pattern Detector circuit to detect two complete bytes.

Any deviation from the above-mentioned one-zero pattern at any time before PLL Lock is detected will reset the PLL Lock Detector. The lock detection procedure will then start again.

- 8. MFM Decoder: The MFM Decoder receives synchronized MFM data from the Pulse Gate and converts it to NRZ READ DATA. For run-length-limited codes the MFM Decoder and Missing Clock Detector will not be used.
- 9. Missing Clock Detector: This block is only required for soft-sectored drives, and is used to detect a missing clock violation of the MFM pattern. The missing clock is inserted when writing to soft-sectored disks to indicate the location of the Address Mark in both the ID and the Data fields of each sector. Once PLL Lock has been indicated, the Missing Clock Detector circuit is enabled. MISSING CLOCK DE-TECTED will go active only if the incoming data pattern contains one suppressed clock bit framed by two adjacent clock bits. The output signal goes high for one cycle of READ CLOCK.

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10. Clock Multiplexer and Deglitcher: When the SET PLL LOCK input changes state this circuit switches the source of the READ CLOCK signal between the half 2f-CLOCK frequency and the half VCO CLOCK frequency. A deglitcher circuit is utilized to ensure that no short clock periods occur during either switchover.

#### **BIT-JITTER TOLERANCE**

The three options of the DP8460, the -4, -3 and -2 offer decreasing window errors (respectively) so that the parts may be selected for different data rates (up to 25Mbit/sec). The -4 part will be used in most low data rate applications. As an example, at the 5Mbit/sec data rate of most 5½ inch drives, T = 200ns so that from the Electrical Characteristics Table, t<sub>WINDOW</sub> = (4 + (1% of 200ns)) or 6ns. The chip therefore contributes up to 6ns of window error, out of the total allowable error of 50ns (half the 2f-clock period of 100ns). This allows the disk drive to have a margin of 44ns of jitter on the transition position before an error will occur.

#### **ANALOG CONNECTIONS TO THE DP8460**

External passive components are required for the Pulse Gate, Charge Pump, Loop Filter and VCO as shown in Figure 5. The information provided here is for guidelines only. The user should select values according to his own system requirements. Phase-Locked Loops are complex circuits that require detailed knowledge of the specific system. Factors such as loop gain, stability, response to change of signal, lock-on time, etc are all determined by the external components. In many disk systems these factors are critical, and National Semiconductor recommends the designer be knowledgeable of phase-locked-loops, or seek the advice of an expert. Inaccurate design will probably result in excessive disk error rates. The phase-locked-loop in the DP8460 has many advantages over all but the most sophisticated discrete designs, and if the component values are selected correctly, it will offer significant performance advantages. This should result in a reduction of disk error rates over equivalent discrete designs.

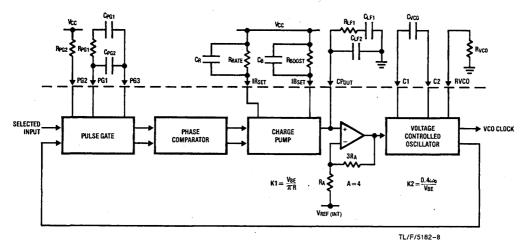


FIGURE 5. Phase-Locked-Loop Section

#### **Pulse Gate**

There are four external components connected to the Pulse Gate as shown in Figure 6 with the associated internal components. The values of  $R_{PG1},\ R_{PG2},\ C_{PG1},\ and\ C_{PG2}$  are dependent on the data rate.  $R_{PG1}$  is proportional to the data rate, while  $R_{PG2},\ C_{PG1}$  and  $C_{PG2}$  are inversely proportional. Table I shows component values for the data rates given. For other data rates, use the equations  $R_{PG1}=(TBD\times f_{VCO})\ k\Omega,\ R_{PG2}=((TDB/f_{VCO})-0.89)\ k\Omega,\ C_{PG1}=(TBD/f_{VCO})\ pF$  and  $C_{PG2}=(TBD/f_{VCO})\ pF$ , where  $f_{VCO}$  is the VCO frequency in MHz. As an example, at 5Mbits/sec data rate,  $f_{VCO}=10\ MHz$ . This produces  $R_{PG1}=...\ k\Omega,\ R_{PG2}=...\ k\Omega,\ C_{PG1}=...\ pF$  and  $C_{PG2}=...\ pF$ . Components with 5% tolerance will suffice.

Data Rate	R <sub>PG2</sub>	R <sub>PG1</sub>	C <sub>PG1</sub>	C <sub>PG2</sub>
2Mbit/sec	16kΩ			
5Mbit/sec	4.7kΩ			
10Mbit/sec	1.9kΩ			
15Mbit/sec	750Ω			
20Mbit/sec	300Ω	• •		
25Mbit/sec	0		,	

**TABLE I. Pulse Gate Component Selection Chart** 

#### Charge Pump

Resistors  $R_{RATE}$  and  $R_{BOOST}$  determine the charge pump current. The Charge Pump bidirectional output current is approximately (within  $\pm 10\%$ ) twice the input current. In the high tracking rate with SET PLL LOCK high, the input current is  $I_{BSET} + I_{RSET}$ , is, the sum of the currents through  $R_{BOOST}$  and  $R_{RATE}$  from Vcc. In the low tracking rate, with SET PLL LOCK low, this input current is  $I_{RSET}$  only.

A recommended approach would be to select RBATE first. The External Component Limits table allows RRATE to be 1.2k $\Omega$  to 6.5k $\Omega$ , so for simplicity select R<sub>RATE</sub> = 3.3k $\Omega$ . A typical loop gain change of 4:1 for high to low tracking rate would require  $R_{BOOST} = R_{RATE} / 3$  or  $1.1k\Omega$ . Referring to Figure 7 the input current is effectively VBE / RRATE in the low tracking rate, where VBE is an internal voltage. This means that the current into or out of the loop filter is approximately 2 VBE / RRATE, or in this example approximately 0.4mA. Note that although it would seem the overall gain is dependent on VBE, this is not the case. The loop gain is altered internally by an amount inversely proportional to V<sub>BF</sub>, as detailed in the section on the Loop Filter. This means that as VBE varies with temperature or device spread, the gain will remain constant for a particular fixed values of RRATE and RBOOST. This alleviates the need for potentiometers to select values for each device. The tolerance required for these two resistors will depend on the total loop gain tolerance allowed, but 5% would be typical. Also Vcc by-pass capacitors are required for these two resistors. A value of 1000pF is suitable for each.

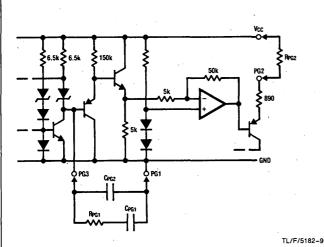


FIGURE 6. Pulse Gate Controls

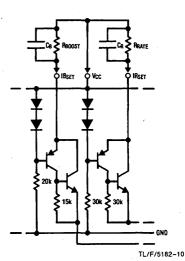


FIGURE 7. IRATE Set and IBOOST Set

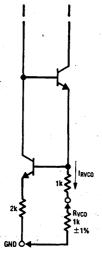
#### vco

The value of  $R_{VCO}$  is fixed at 1  $k\Omega$  ±1% in the External Component Limits table. This requires a resistor more accurate than 1% to allow for temperature variations. Figure 8 shows how  $R_{VCO}$  is connected to the internal components of the chip. This value was fixed at  $1k\Omega$  to set the VCO operating current such that optimum performance of the VCO is obtained for production device spreads. This means fixed value components will be adequate to set the VCO center frequency for production runs. The value of  $C_{VCO}$  can therefore be determined from the VCO frequency fvCo, using the equation:  $C_{VCO}=1$  /  $(R_{VCO})$  (fvCo) where fvCo is twice the input data rate. As an example, for a 5Mbit/sec data rate, fvCO = 10Mhz, requiring that  $C_{VCO}=100pF$ . The

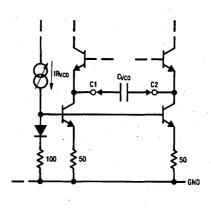
capacitor tolerance also should be better than 1%. The capacitor is connected to internal circuitry of the chip as shown in *Figure 9*.

This equation does not cover the whole range of data rates. As the data rate increases and  $C_{VCO}$  gets smaller, the effects of unwanted parasitic capacitances influence the frequency. As a guide the graph of *Figure 10* shows approximately the value of  $C_{VCO}$  for a given data rate.

The center frequency may be checked by applying pulses at the ENCODED DATA input with READ GATE set high. The input frequency should be varied above and below the chosen center frequency until the VCO stops tracking. Typically this will be 20% either side of the center frequency.



TL/F/5182-11
FIGURE 8. VCO Current Setting Resistor



TL/F/5182-12



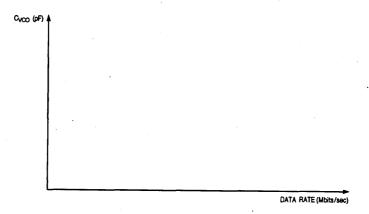


FIGURE 10, VCO Capacitor Value for Disk Data Rates

TL/F/5182-13

#### Loop Filter

The input current into the Buffer Amplifier is offset by a matched current out of the Charge Pump, and even so is much less than the switching current in or out of the Charge Pump. It can therefore be assumed that all the Charge Pump switching current goes into the Loop Filter components  $R_{LF1}$  and  $C_{LF1}$  and  $C_{LF2}$ . The tolerance of these components should be the same as  $R_{RATE}$  and  $R_{BOOST}$ , and will determine the overall loop gain variation. The three components connected to the Charge Pump output are shown in Figure 11. Note the return current goes to analog GND, which should be electrically very close to the GND pin itself.

The value of capacitor  $C_{LF1}$  basically determines loop stability-the larger the value the longer the loop takes to respond to an input change. If  $C_{LF1}$  is too small, the loop will track any jitter on the ENCODED DATA input and the VCO output will follow this jitter, which is undesirable. The value of  $C_{LF1}$  should therefore be large enough so that the PLL is fairly immune to phase jitter but not large enough that the loop won't respond to longer term data rate changes that occur on the disk drive.

The damping resistor  $R_{LF1}$  is required to damp any oscillation on the VCO input that would otherwise occur due to step function changes on the input. A value of  $R_{LF1}$  that would give a phase margin of around 45 degrees would be a reasonable starting point.

The main function of the capacitor  $C_{LF2}$  is to integrate the effects of the VCO frequency on the VCO input voltage. Typically its value will be about one tenth of  $C_{LF1}$ .

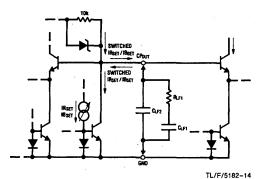
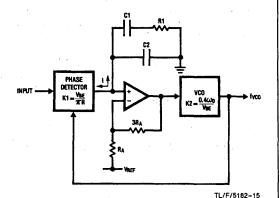


FIGURE 11. Charge Pump Out



**FIGURE 12. Loop Response Components** 

Figure 12 shows the relevant phase-locked-loop blocks that determine system response, namely the Phase Detector. Filter/Buffer Amplifier, and VCO. The Phase Detector (Phase Comparator and Charge Pump) produces an aggregate output current i which is proportional to the phase difference between the input signal and the VCO signal. The constant (K<sub>1</sub>) is  $V_{BE}/\pi R$  amps per radian. R is either  $R_{RATE}$ or RRATE RBOOST. This aggregate current feeds into or out of the filter impedance (Z), producing a voltage to the VCO that regulates the VCO frequency. The VCO gain constant is 0.4 ω<sub>VCO</sub>/V<sub>BE</sub> radians per second per volt. Under steady state conditions, i will be zero and there will be no phase difference between the input signal and the VCO. Any change of input signal will produce a change in VCO frequency that is determined by the loop gain equation. This equation is determined from the gain constants K1, A and K2 and the filter v/i response.

The impedance Z of the filter is:

$$\frac{1}{sC_2} \parallel \left( \frac{1}{sC_1} + R_1 \right) = \frac{1 + sC_1R_1}{sC_1(1 + \frac{C_2}{C_4} + sC_2R_1)}$$

$$\frac{1 + sC_1R_1}{sC_1 (1 + sC_2R_1)}$$

The overall loop gain is then G(s)=  $\frac{K_1AK_2}{s} \times \frac{1 + sC_1R_1}{sC_1(1 + sC_2R_1)}$ 

The desired Bode plot of gain and phase is shown in Figure 13, with -20dB/decade slope at  $\omega_O$  for stability at unity gain.

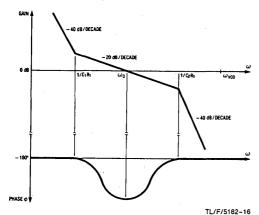


FIGURE 13. Bode Plot of Loop Response

If the point of inflexion of the phase curve is at  $\omega_0$ , (the loop natural frequency and therefore the closed loop bandwidth), then it can be shown that for a phase margin  $\phi$ ,

$$C_2R_1 = \frac{1 - \sin \phi}{\omega_0 \cos \phi} \sec$$

$$C_1R_1 = \frac{1}{\omega_0^2 C_2 R_1} sec$$

and 
$$C_1 = \frac{K_1 A K_2}{\omega_0^2} \times \frac{1 + \omega_0 C_1 R_1}{1 + \omega_0 C_2 R_1} F$$

As an example, if we want the PLL to lock-on within two bytes of preamble in the high tracking rate mode, and the disk data rate is 5Mbits/sec, or one bit every 200ns.

(Thus 
$$f_{VCO} = 10MHz$$
)

time to lock = 
$$16 \times 0.2 \mu s$$
 =  $3.2 \mu s$ 

Closed loop bandwidth  $f_{\mbox{\scriptsize O}}\!>$  (0.3/3.2) MHz or about 100kHz

(the factor 0.3 is a rule of thumb guideline derived from the product of rise time and bandwidth).

Select a bandwidth  $f_O$  = 200kHz so that  $\omega_O$  =  $2\pi \times$  200kHz (giving a ratio of  $f_{VCO}$  /  $f_O$  = 50)

Select a phase margin  $\phi$  between 30° and 70° for stability. Choose  $\phi$  = 45° for optimum response

Then 
$$C_2R_1 = \frac{(1 - \sin 45^\circ)}{2\pi \times 200 \times 10^3 \times \cos 45^\circ} = 0.33 \times 10^{-6} \text{ sec}$$

and 
$$C_1R_1 = \frac{1}{(2\pi \times 200 \times 10^3)^2 \times 0.33 \times 10^{-6}} = 1.92 \times 10^{-6} \text{ sec}$$

To determine C1, we need to know K1, A and K2.

$$K_1 = \frac{V_{BE}}{\pi R}$$
 amps per radian

In the high tracking rate, R = 1.1k  $\parallel$  3.3k = 825 $\Omega$  for our example from the Charge Pump calculations

So K<sub>1</sub> = 
$$\frac{V_{BE}}{\pi \times 825}$$
 amps/radian

the Buffer Amplifier gain A is internally set to 4.0

$$K_2 = \frac{0.4\omega_{VCO}}{V_{BE}}$$
 radians per sec per volt

$$K_2 = \frac{0.4 \times 2\pi \times 10^7}{V_{BE}}$$
 radians per sec per volt

so C<sub>1</sub> = 
$$\frac{V_{BE}}{\pi \times 825} \times 4.0 \times \frac{0.4 \times 2\pi \times 10^7}{V_{BE} \times (2\pi \times 200 \times 10^3)^2} \times$$

$$\frac{1 + (2\pi \times 200 \times 10^{3} \times 1.92 \times 10^{-6})}{1 + (2\pi \times 200 \times 10^{3} \times 0.33 \times 10^{-6})} \text{ F}$$

The  $V_{BE}$  in the  $K_1$  equation cancels with the  $V_{BE}$  in the  $K_2$  equation provided good matching is maintained on the DP8460.

Thus  $C_1 = 5.923 \times 10^{-8} F$ . Select  $C_1$  to be  $0.056 \mu F$ 

.. 
$$R_1 = \frac{1.92 \times 10^{-6}}{56000 \times 10^{-12}} \Omega = 34.28\Omega$$
. Select  $R_1 = 33\Omega$ 

$$\therefore C_2 = \frac{0.33 \times 10^{-6}}{33} \text{ F} = 10^{-8} \text{F} = 0.01 \mu\text{F}. \text{ Select } C_2 = 0.01 \mu\text{F}$$

The calculated values are only a guide, the user should then empirically test the loop and determine stability, lock-on time, jitter tolerance, etc. .

Note that capacitor  $C_2$  affects the amount by which the Charge Pump switching current affects the filter voltage. Obviously as  $C_2$  is increased in value ripple will decrease, but the closer the -40dB/decade slope gets to  $\omega_0$  on the Bode plot the more unstable the loop will be. Thus if  $C_2$  is made too large the loop will oscillate.

Resistor R<sub>1</sub> determines where the low-frequency end -40dB/decade slope changes into the -20dB/decade slope. The wider the -20dB/decade slope is around unity gain, the more stable the loop becomes. If R<sub>1</sub> is too large it will reduce the impact of C<sub>1</sub>, while too small a value will increase instability. The capacitor C<sub>1</sub> strongly effects the response of the loop. Too high a value will slow down the response time, but make it less prone to jitter or frequency shift whereas too low a value will improve response time while tending to react to jitter.

Other filter combinations may be used, other than  $R_{LF1}$  in series with  $C_{LF1}$ , all in parallel with  $C_{LF2}$ . For example the filter shown in *Figure 14* will also perform similarly, and in fact for some systems it will yield superior performance.

#### **DIGITAL CONNECTIONS TO THE DP8460**

Figure 17 shows a connection diagram for the DP8460 in a typical application. All logic inputs and outputs are TTL compatible as shown in Figures 15 and 16. The VCO CLOCK output is 74AS compatible and can therefore drive up to 40 74AS (or 74F) inputs, or 10 74S inputs, or 100 74ALS inputs, or 50 of 74LS inputs. All other outputs are 74ALS compatible and so will drive up to 16 74AS inputs, or 4 74S inputs, or 40 74ALS inputs or 20 74LS inputs. All inputs are 74ALS compatible and therefore can be driven easily from any 74 series devices. The raw MFM from the pulse detector in the drive is connected to the ENCODED DATA input. The DE-LAY DISABLE input determines whether attempting lock-on will begin immediately after READ GATE is set or after 2 bytes. Typically in a hard-sectored drive, READ GATE is set active as the sector pulse appears, meaning a new sector is about to pass under the head. Normally the preamble pattern does not begin immediately, because gap bytes from the preceding sector usually extend just beyond the sector pulse. Allowing 2 bytes to pass after the sector pulse helps ensure that the PLL will begin locking on to preamble, and will not be chasing non-symmetrical gap bits. Attempting to lock-on to a fixed ....1010.... preamble pattern speeds up lock-on, and after another two bytes the PLL will nominally have locked-on. Thus DELAY DISABLE should be set low for this kind of disk drive.

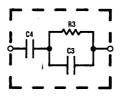


FIGURE 14. Alternate Loop Filter Configuration

TL/F/5182-17

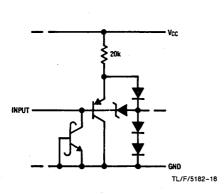


FIGURE 15. Logic Inputs

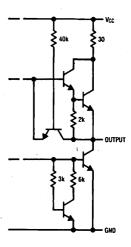


FIGURE 16. Logic Outputs

TL/F/5182-19

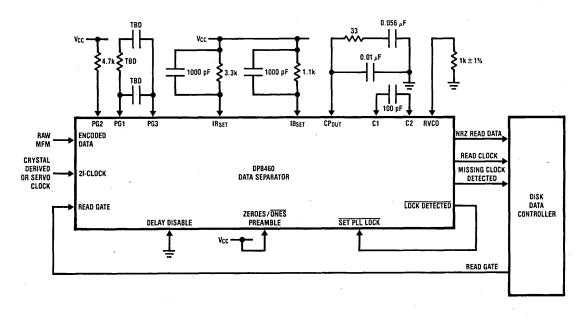


FIGURE 17. Typical Connection to DP8460 for:

- 1) MFM Data Input, 5Mbit/sec Data Rate
- 2) 32 Bit Delay to Enable
- 3) All Zeroes (NRZ) Preamble

For soft sectored drives, the controller normally will not wait for the index pulse before it attempts lock-on, so that READ GATE may go active at any time. Chances are the head will not be over a preamble field and therefore there is no need to wait 2 bytes before attempting lock-on. DELAY DISABLE can therefore be set high. If a non-preamble field is passing by as READ GATE goes active, the DP8460 will not indicate lock, and no data decoding will occur nor will MISSING CLOCK DETECTED go active. Normally, if lock-on has not been achieved after a certain time limit, the controller will de-activate READ GATE and then try again.

For MFM encoded disk drives, the LOCK DETECTED output will be connected back to the SET PLL LOCK input. As the PLL achieves lock-on, the DP8460 will automatically switch to the slower tracking rate and decoded data will appear at the NRZ READ DATA output. Also the READ CLOCK output will switch from half the 2f-clock frequency to the disk data rate frequency. If a delay is required before the changeover occurs, a time delay may be inserted between the two pins.

Some drives have an all-ONES data preamble instead of all-ZEROES and the DP8460 must be set to the type being used before it can properly decode data. The ZEROES/ONES PREAMBLE input selects which preamble type the chip is to lock-on to.

If the drive uses a run-length-limited (RLL) code such as '2, 7', instead of MFM, the phase-locked-loop function of the DP8460 may still be used. Figure 18 shows how the DP8460 may be connected to a RLL ENDEC circuit. The RLL ENDEC performs encoding of NRZ data to RLL encoded data, and RLL encoded data back to NRZ data. The RLL ENDEC can use the SYNCHRONIZED DATA output of the DP8460 along with VCO CLOCK to lock-on to the preamble and then decode data. Once lock-on has been detected, the RLL ENDEC can set the SET PLL LOCK input of the DP8460 low so that the tracking rate can be changed.

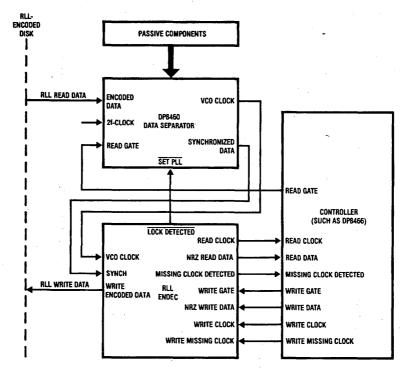


FIGURE 18. DP8460 with Run-Length-Limited (RLL) Codes

TL/F/5182-21

#### **APPLICATIONS OF THE DP8460 DATA SEPARATOR**

The DP8460 is the first integrated circuit to place on one chip a PLL with features that offer the improved speed and reliability required by the disk industry. Not only does the chip simplify disk system design, but also provides fast lock-on to the incoming preamble. Once locked on, the loop is set into a more stable mode. This inherent loop stability allows for a sizeable amount of jitter on the data stream, such as is encountered in many disk systems. Once in the stable tracking rate, the SYNCHRONIZED DATA output represents the incoming ENCODED DATA and is synchronous with VCO CLOCK. If the disk is MFM encoded, then the chip can decode the synchronized data into NRZ READ DATA and READ CLOCK. These are available as outputs from the chip allowing the NRZ READ DATA to be deserialized using the READ CLOCK.

The DP8460 is capable of operating at up to 25Mbits/sec data rates and so is compatible with a wide assortment of disk drives. The faster data rates of the 8-inch and 14-inch disk drives will mandate the selection of either the

DP8460-3 or -2 parts with their narrower window margins on the incoming data stream. This will also be the case when 5½-inch drives achieve higher data rates. Some 8-inch and 14-inch disk drives incorporate the functions of the DP8460, but use many discrete ICs. In these cases, replacing these components with the DP8460 will offer reduced P.C. board area, lower cost, and improved performance while simplifying circuit testing.

Most 51/4-inch and many 8-inch and 14-inch disk drives manufactured at present do not incorporate any of the functions of the DP8460. This is so primarily because the PLL function is difficult to design and implement, and requires circuitry which covers a large area of the printed circuit card. This is undesirable both from the drive size aspect and from the cost aspect (the cost includes soldering, testing, and adjusting the components). Consequently, most smaller disk drives output MFM encoded data so that the phase-locked-loop and data separation have to be performed by the controller. The DP8460 will therefore replace these functions in controller designs, as shown in Figure 19.

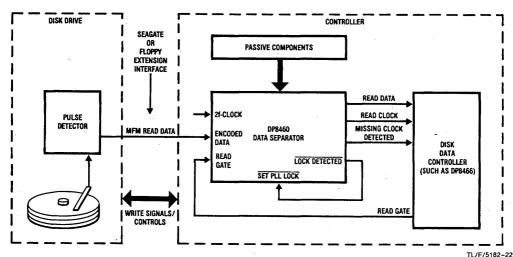


FIGURE 19. DP8460 in the Controller

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System design criteria may now change because the DP8460 is a one-chip solution, requiring only a few external passive components with fixed values. It operates from a +5V supply, consumes about 0.5W, and is housed in a narrow 24-pin package. The circuitry has been designed so that the external resistors and capacitors need not be adjustable; the user chooses the values according to the disk drive requirements. Once selected, they will be fixed for that particular drive type. These features make it possible to transfer these functions to the disk drive, as shown in Figure 20. Apart from a slight increase in board area, the advantages outweigh the disadvantages. First, the components selected are fixed for each type of drive and this facilitates the problem of interchangeability of drives. At present, controllers are adjusted to function with each specific drive; with the DP8460 in the drive, component adjustment will no longer be required. Second there is often a problem of reliability of data transfer. Because the MFM data is clock encoded. this signal is susceptible to noise, bit shift, etc. Soft errors will sometimes occur when the incoming disk data bit position is outside the Pulse Gate window as it is being synchronized to the VCO clock in the phase-locked-loop. Obviously, the nearer the PLL is to the MFM source, the less chance there is that errors will occur. Thus placing the DP8460 in the drive will increase the reliability of data transfer within the sysem.

A third advantage is data rate upgrading. Most 51/4-inch drives have 5Mbit/sec data rate because the early drives were made with this data rate. This meant the controllers had to be designed with PLLs which operate at this data rate. It is therefore difficult for drive manufacturers to introduce new drives that are not compatible with existing controllers. Since no new standard data rate has emerged, they must continue to produce drives at this data rate to be compatible with the controllers on the market. With the DP8460 in the drive, and its associated components set for the drive's data rate, it no longer becomes a problem to increase the data rate, assuming the controllers digital circuitry can accommodate the change. This will allow the manufacturers to increase the bit density and therefore the capacity of their drives.

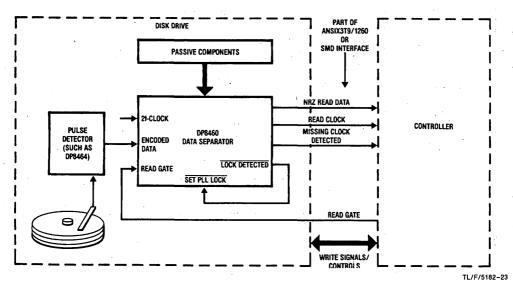


FIGURE 20. DP8460 in the Disk Drive

## Disk Support PRELIMINARY

## **DP8464 Disk Pulse Detector**

## **General Description**

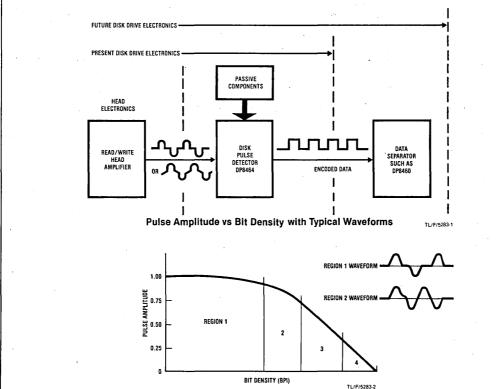
The DP8464 disk pulse detector utilizes analog and digital circuitry to detect amplitude peaks of the signal received from the read/write amplifier fitted in the heads of disk drives. The DP8464 produces a TTL compatible output which, on the positive edge, indicates a signal peak. Electrically, these peaks correspond to 1s or flux reversals on the magnetic medium. The signal received when reading a disk is therefore a series of pulses which alternate in polarity. The disk pulse detector must accurately determine the time positions of these peaks. This task is complicated by variable pulse amplitudes depending on the media type, head position, head type, and read/write amplifier circuit gain. Additionally, as the bit density on the disk increases the amplitude decreases and significant bit interaction occurs resulting in pulse distortion.

The graph below shows how pulse amplitude varies with the number of bits per inch (or recording density). The predominant disk applications are associated with the first two regions on the graph, regions 1 and 2. Typical waveforms received by the pulse detector for regions 1 and 2 operation are shown next to the graph. A region 1 signal is characterized by the waveform returning to the baseline between pulses. A region 2 waveform will go from a tendency to return to the baseline (called shouldering) to almost sinusoidal at the higher frequencies.

The disk pulse detector is fabricated using the advanced Schottky process, and has been designed to function with data rates up to 25 megabits/second. The DP8464 is housed in a standard narrow 24-pin package. Normally, it will be fitted in the disk drive, and its output may be directly connected to the DP8460 data separator.

### **Features**

- Connects directly with the disk head read/write amplifier
- Wide input signal amplitude range—from 20 mVpp to 600 mVpp differential
- Data rates up to 25 Mbits/sec
- On-chip wideband differential AGC amplifier, differentiator, comparator gating circuitry, output pulse generator
- Adjustable comparator threshold
- Selectable attack and differentiator capacitors
- Inputs and outputs TTL compatible
- Output may connect directly to the DP8460 data separator
- Standard narrow 24-pin dual-in-line package
- Standard supply: 12V ± 10%



## **Functional Description**

#### **DETECTOR OPERATION**

Region 1 is the high resolution area characterized by a large spread between flux reversals and a definite return to baseline (no signal) between these peaks. Pulses of this type are predominantly found in systems which use thin film heads, plated media and systems which utilize runlength-limited coding techniques (like the 2,7 code) which spread the distance between flux reversals.

The main circuit blocks of the DP8464 are shown in Figure 1. The output from the read/write amplifier is fed directly to the amplifier input of the DP8464. This amplifier is a high bandwidth amplifier with automatic gain control (AGC). The amplifier's output voltage is fed back via an external filter to an internal fullwave rectifier and compared against the external voltage on the V<sub>REF</sub> pin. The AGC circuit adjusts the gain of the amplifier to make the peak to peak differential analog output four times the voltage on V<sub>REF</sub>. The circuit is designed for a V<sub>REF</sub> of 1V which produces constant 4V peak to peak differential output for differential input signals ranging from 20 mVpp to 300 mVpp.

The peak detection is performed by feeding the output of the wideband amplifier through an external filter to the differentiator. The differentiator output changes state when the input pulse changes direction, generally this will be at the peaks. However, if the signal exhibits shouldering (the tendency to return to the baseline) as seen in region 1 and the upper part of region 2, the differentiator will also respond to noise near the baseline. To avoid this, the signal is also fed to a comparator which is used to define a level around the baseline. Data detection is prevented when the input is less than this level. The threshold for this comparator is externally set via the SET THRESHOLD pin. The comparator output feeds the hold input of the differentiator. The output of the differentiator then drives the bidirectional one-shot. A 4 Vpp differential output voltage will produce a 1V fullwave rectified signal at the input of the comparator. Therefore, if the voltage on the SET THRESHOLD pin is 0.3V, the input must be larger than ± 300 mV before the differentiator is allowed to trigger the one-shot. This comparator circuit thus acts as a gating channel to prevent any noise near the baseline from contaminating the data. The diff output, encoded data, and comp out are all standard TTL outputs. The pulse width of the encoded data can be adjusted from 20 ns to 200 ns via the set pulse width.

The timing of the gating channel with respect to the differentiator output is critical. If the delay through the comparator is longer than the delay through the differentiator, then the window is not centered around the peak of the waveform and the circuit will not perform optimally. The correct operation is to have the differentiator output switch in the middle of the comparator output waveform. Often, to make the differentiator less sensitive to high frequency noise, an RLC filter will be used in place of the differentiator capacitor. This will increase the delay time through the differentiator. To cancel out the effect of this delay, an external delay can be inserted between comp out and diff hold.

Offset of the differentiator is critical to the performance of the circuit. Offset will cause "pulse pairing" which simply means that every other pulse is delayed. This happens because a positive offset will delay all the positive pulses. This obviously will ruin the encoded data. The DP8464 provides two  $C_{\text{OFFSET}}$  pins for an external capacitor. This capacitor will bandlimit the differential signal going into offset adjust circuitry in the differentiator. In this way, the differentiator is actively corrected to eliminate the initial offset and drift with temperature and time.

The wideband amplifier output is provided to allow the use of external filters to the differentiator and to the AGC circuit. The filter to the differentiator enables the user to limit the bandwidth for noise considerations. The filter to the AGC circuit allows the user to insert a lead network to prevent the AGC amplifier from responding to frequency induced amplitude changes.

The DP8464 has a READ/WRITE control pin which is used to minimize the effect on the AGC amplifier of a write-to-read transition. This allows a reduction in the size of the track gap on disk. This pin may be connected to the WRITE GATE output of the DP8466 disk data controller.

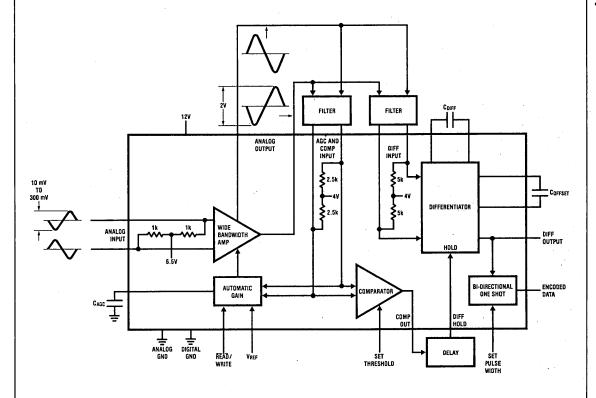


FIGURE 1. Pulse Detector Block Diagram

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TL/F/5283-3

## Disk Support PRELIMINARY

## **DP8466 Disk Data Controller**

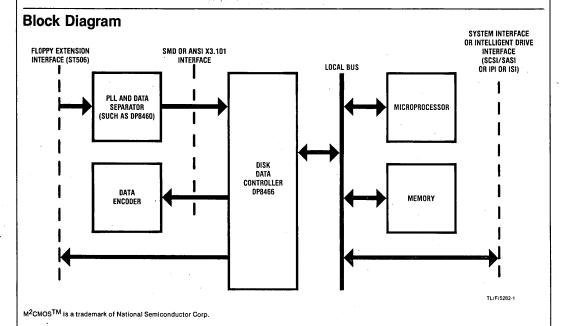
## **General Description**

The disk data controller (DDC) performs many of the functions in the data path electronics of either disk controllers or intelligent disk drives. It interfaces between serial data on the disk side and the memory/microprocessor bus on the system side. The primary function of the chip is to correctly identify the selected sector on disk and then transfer the sector's data to or from memory, utilizing a 32-byte (16-word) FIFO buffer with optional DMA control. The 48-pin chip is fabricated using the M²CMOS<sup>TM</sup> process, which allows complex functions to be implemented with high operating speeds and modest power consumption. Internal gate delays of 2 ns allow the DDC to function with data rates over 24 Mbits/sec, enabling it to be used with all sizes of Winchester and floppy disk drives.

The disk side of the DDC interfaces directly with drives compatible with the ESDI, SMD or ANSI X3.101 interfaces. If the DDC is part of a controller that interfaces directly to the ST506 (floppy extension interface), then the DP8460 data separator may be used and its signals will connect directly to the DDC. The DDC may be part of an intelligent disk drive that has SCSI (SASI) or IPI or ISI compatible interfaces.

### **Features**

- Useable with Winchester, floppy, optical and vertically recorded drives
- Disk data rates up to 24 Mbits/sec
- Meets requirements of all standard disk drive interfaces
- User programmable format
- Compatible with all disk drive sizes, fixed or removable
- Compatible with hard and soft sectored drives
- Single or multiple sector operation
- Independent header and data operations
- Internal CRC or ECC, or external ECC, for header and data
- Internal ECC has programmable polynomial and correction span
- Configurable for disk formatting
- System side interfaces to memory and microprocessor
- Easily controlled by popular 8-bit or 16-bit microprocessors
- 8 or 16-bit wide memory transfers
- Internal data buffering with 32-byte FIFO
- Single channel 32-bit or dual channel 16-bit DMA controller
- Powerful data path diagnostics
- Low power consumption at lower data rates and standby
- Single +5V power supply
- Standard 48-pin DIP



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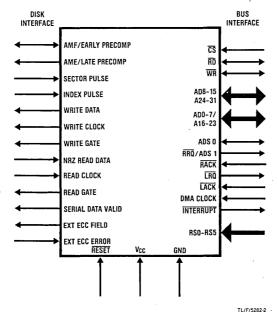
The system side of the DDC may interface directly to the main system bus, or the local bus of a larger system. The DDC has a 16-bit I/O bus and associated microprocessor/DMA handshake signals. The I/O bus is used both for disk data transfers to or from memory (user-selectable for 8 or 16 data bits) and for microprocessor access. The microprocessor may have a multiplexed or separate address and data bus. The DDC has two DMA channels available for memory transfer operations. In a typical low-end system the DDC connects directly to the main system bus, and only one DMA channel is required to output memory addresses. The on-chip DMA issues the address on the I/O bus, followed by the data to be transferred between the DDC and memory. The DDC has variable burst transfer length capability that allows microprocessor usage of the bus during transfer operations. The DDC supports a second mode of DMA capability which is ideal for intelligent disk drives or higher-end systems that use a buffer memory. One DMA channel controls disk-memory transfers, and the second controls memory-system transfers.

To be compatible with the differing needs of these disk drives, the DDC has been configured so that the format and mode of operation are user programmable. The user selects the length and pattern of the preamble, address mark (if required), synch, postamble, and gap of both the ID and data segments of the sector. At system initialization, the microprocessor loads these parameters into the parameter RAM of the DDC. For normal transactions such as reading from or writing to the disk, the desired ID bytes must first be loaded into the DDC, followed by the disk drive command. The DDC can also be configured to format disks.

Extensive diagnostic and interrogation features are provided on-chip. CRC or ECC calculations are performed on both the ID and data segments that pass through the DDC. The ECC code may be an internally generated 32-bit fully programmable ECC code or up to 15 bytes of externally generated ECC code. The DDC contains status and error registers that can be accessed by the microprocessor.

Control functions not in the data path electronics have been omitted to allow for versatility in interfacing to different drive requirements. The drive control signals may be provided by either a dedicated microcontroller or a microprocessor I/O port.

### **DDC Connection Diagram** (48 pins)







## Section 11 Frequency Synthesis



DEVICE	DESCRIPTION	PAGE NUMBER
DS8906	AM/FM Digital Phase-Locked Loop Frequency Synthesizer	11-4
DS8907	AM/FM Digital Phase-Locked Loop Frequency Synthesizer	11-10
DS8908	AM/FM Digital Phase-Locked Loop Frequency Synthesizer	11-16
DS8614	130/225 MHz Low Power Dual Modulus Prescalers	11-23
DS8615	130/225 MHz Low Power Dual Modulus Prescalers	11-23
DS8616	130/225 MHz Low Power Dual Modulus Prescalers	11-23
DS8617	130/225 MHz Low Power Dual Modulus Prescalers	11-23
DS8626	120 MHz Divide-by-40 Prescaler	11-27
DS8629	120 MHz Divide-by-100 Prescaler	11-27
DS8627	130/225 MHz Low Power Prescalers	11-30
DS8628	130/225 MHz Low Power Prescalers	11-30
DS8621	275 MHz/1.2 GHz VHF/UHF Prescaler	11-33
DS8622	500 MHz/1.2 GHz Dual Modulus VHF/UHF Prescaler	11-36
AN-335	Digital PLL Synthesis	11-40

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## Frequency Synthesizers Selection Guide

Product Type	Frequency Bands	Power (mA)	Tuning Resolution	Page No.
PLL FREQUENCY	SYNTHESIZERS			
DS8906	AM/FM	160	500 Hz/12.5 kHz	11-4
DS8907	AM/FM	160	10 kHz/25 kHz	11-10
DS8908	AM/FM	. 160	1 kHz, 9 kHz, 10 kHz, 20 kHz	11-16
AN-335 Digital PLL Synthesis				11-40

Product Type	Divide Modulus	Power (mA)	f <sub>MAX</sub>	Page No.
HIGH FREQUENCY	PRESCALERS			
Single (Fixed) Mod	dulus Dividers			
DS8626	÷ 40	125	120 MHz	11-27
DS8627	÷ 24	7/10	130/225 MHz	11-30
DS8628	÷ 20	7/10	130/225 MHz	11-30
DS8629	÷ 100	135	120 MHz	11-27
DS8621	÷ 64, ÷ 256	32	275 MHz, 1.2 GHz	11-33
Dual-Modulus Div	iders			
DS8614	÷ 20/21	7/10	130/225 MHz	11-23
DS8615	÷ 32/33	7/10	130/225 MHz	11-23
DS8616	÷ 40/41	7/10	130/225 MHz	11-23
DS8617	÷ 64/65	7/10	130/225 MHz	11-23
DS8622	÷ 126/128, ÷ 252/256	32	550 MHz, 1.2 GHz	11-36

# National Semiconductor

## **Frequency Synthesis**

## DS8906 AM/FM Digital Phase-Locked Loop Synthesizer

#### **General Description**

The DS8906 is a PLL synthesizer designed specifically for use in AM/FM radios. It contains the reference oscillator, a phase comparator, a charge pump, a 120 MHz ECL/1<sup>2</sup>L dual modulus programmable divider, and a 20-bit shift register/latch for serial data entry. The device is designed to operate with a serial data controller generating the necessary division codes for each frequency, and logic state information for radio function inputs/outputs.

The Colpitts reference oscillator for the PLL operates at 4 MHz. A chain of dividers is used to generate a 500 kHz clock signal for the external controller. Additional dividers generate a 12.5 kHz reference signal for FM and a 500 Hz reference signal for AM/SW. One of these reference signals is selected by the data from the controller for use by the phase comparator. Additional dividers are used to generate a 50 Hz timing signal used by the controller for "time-of-day".

Data is transferred between the frequency synthesizer and the controller via a 3 wire bus system. This consists of a data input line, an enable line, and a clock line. When the enable line is low, data can be shifted from the controller into the frequency synthesizer. When the enable line is transitioned from low to high, data entry is disabled and data present in the shift register is latched.

From the controller 22-bit data stream, the first 2 bits address the device permitting other devices to share the same bus. Of the remaining 20-bit data word, the next 14-bits are used for the PLL divide code. The remaining 6 bits are connected via latches to output pins. These 6 bits can be used to drive radio functions such as gain, mute, FM, AM, LW and SW only. These outputs are open collector. Bit 18 is used internally to select the AM or FM local oscillator input and to select between the 500 Hz and 12.5 kHz reference. A high level at bit 18 indicates FM and a low level indicates AM.

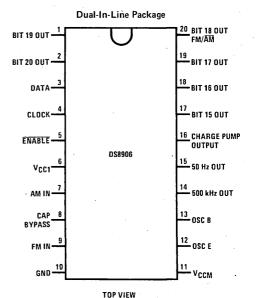
The PLL consists of a 14-bit programmable I<sup>2</sup>L divider, an ECL phase comparator, an ECL dual modulus (p/p + 1) prescaler, and a high speed charge pump. The programmable divider divides by (N+1), N being the number loaded into the shift register (bits 1-14 after address). It is clocked by the AM input via an ECL ÷ 7/8 prescaler, or through a ÷ 63/64 prescaler from the FM input. The AM input will work at frequencies up to 8 MHz, while the FM input works up to 120 MHz. The AM band is tuned with a frequency resolution of 500 Hz and the FM band is tuned with a resolution of 12.5 kHz. The buffered AM and FM inputs are self-biased and can be driven directly by the VCO thru a capacitor. The ECL phase comparator produces very accurate resolution of the phase difference between the input signal and the reference oscillator. The high speed charge pump consists of a switchable constant current source (-0.3 mA) and a switchable constant current sink (+0.3 mA). If the VCO frequency is low, the charge pump will source current, and sink current if the VCO frequency is high.

A separate V<sub>CCM</sub> pin (typically drawing 1.5 mA) powers the oscillator and reference chain to provide controller clocking frequencies when the balance of the PLL is powered down.

#### **Features**

- Uses inexpensive 4 MHz reference crystal
- FIN capability greater than 120 MHz allows direct synthesis at FM frequencies
- FM resolution of 12.5 kHz allows usage of 10.7 MHz ceramic filter distribution.
- Serial data entry for simplified control.
- 50 Hz output for "time-of-day" reference with separate low power supply (VCCM).
- 6-open collector buffered outputs for band switching and other radio functions.
- Separate AM and FM inputs. AM input has 15 mV (typical) hysteresis.

## **Connection Diagram**



Order Number DS8906N See NS Package N20A

Absolute Maximum Ratings (Note 1)		<ul> <li>Operating Con-</li> </ul>	ditions		
			MIN	MAX	UNITS
Supply Voltage		Supply Voltage, VCC			
(V <sub>CC1</sub> )	7V	V <sub>CC1</sub>	4.75	5.25	· V
(VCCM)	7V	VCCM	4.5	6.0	V
Input Voltage	7V	Temperature, TA	0	70	°c
Output Voltage	7V				
Storage Temperature Range	-65°C to +150°C				
Lead Temperature (Soldering, 10 seconds)	300°C				

## DC Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS		MtN	TYP	MAX	UNITS
ViH	Logical "1" Input Voltage			2.1			٧
lін	Logical "1" Input Current	VIN = VCC1			0	10	μА
VIL	Logical "0" Input Voltage					0.7	V
IIL	Logical "0" Input Current	Data, Clock, and ENABLE Inputs	s, V <sub>IN</sub> = 0V		-5	-25	μΑ
ЮН	Logical "1" Output Current All Bit Outputs, 50 Hz Output 500 kHz Output	V <sub>OH</sub> = 5.25V V <sub>OH</sub> = 2.4V, V <sub>CCM</sub> = 4.5V				50 -250	μΑ μΑ
VOL	Logical "0" Output Voltage All Bit Outputs 50 Hz Output, 500 kHz Output	I <sub>OL</sub> = 5 mA I <sub>OL</sub> = 250 μA				0.5 0.5	V
ICC1	Supply Current (V <sub>CC1</sub> )	All Bit Outputs High			90	160	mA
ICCM(STAN	NDBY) VCCM Supply Current	V <sub>CCM</sub> = 6.0V, All Other Pins Ope	en		1.5	4.0	mA
lout	Charge Pump Output Current	$1.2V \le V_{OUT} \le V_{CCM} - 1.2V$	Pump Up	-0.10	-0.30	-0.6	mA
		V <sub>CCM</sub> ≤6.0V	Pump Down	0.10	0.30	0.6	mA
			TRI-STATE®		0	±100	nA
ICCM(OPER	RATE) VCCM Supply Current	V <sub>CCM</sub> = 6.0V, V <sub>CC1</sub> = 5.25V, All Other Pins Open			2.5	6.0	mA

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## AC Electrical Characteristics $V_{CC}$ = 5V, $T_A$ = 25°C, $t_r \le 10$ ns, $t_f \le 10$ ns

	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V <sub>IN(MIN)(F)</sub>	F <sub>IN</sub> Minimum Signal Input	AM and FM Inputs, $0^{\circ}C \le T_{A} \le 70^{\circ}C$		20	100	mV (rms)
VIN(MAX)(F)	F <sub>IN</sub> Maximum Signal Input	AM and FM Inputs, $0^{\circ}$ C $\leq$ TA $\leq$ $70^{\circ}$ C	1000	1500		mV (rms)
FOPERATE	Operating Frequency Range (Sine Wave Input)	$V_{IN}$ = 100 mV rms AM $0^{\circ}$ C $\leq$ TA $\leq$ 70 $^{\circ}$ C FM	0.4 60		8 120	MHz MHz
R <sub>IN</sub> (FM)	AC Input Resistance, FM	120 MHz, V <sub>IN</sub> = 100 mV rms	300			2.
R <sub>IN</sub> (AM)	AC Input Resistance, AM	2 MHz, V <sub>IN</sub> = 100 mV rms	1000			2
CIN	Input Capacitance, FM and AM	V <sub>IN</sub> = 120 MHz	3	6	10	pl
tEN1	Minimum ENABLE High Pulse Width			625	1250	n
<sup>t</sup> EN0	Minimum ENABLE Low Pulse Width			375	750	n
tCLKEN0	Minimum Time Before ENABLE Goes Low that CLOCK Must be Low			-50	0	r
<sup>t</sup> ENOCLK	Minimum Time After ENABLE Goes Low that CLOCK Must Remain Low			275	550	г
tCLKEN1	Minimum Time Before ENABLE Goes High that Last Positive CLOCK Edge May Occur			300	600	n
<sup>t</sup> EN1CLK	Minimum Time After ENABLE Goes High Before an Unused Positive CLOCK Edge May Occur			175	350	n

## AC Electrical Characteristics (Continued) $V_{CC} = 5V$ , $T_A = 25^{\circ}C$ , $t_f \le 10$ ns, $t_f \le 10$ ns

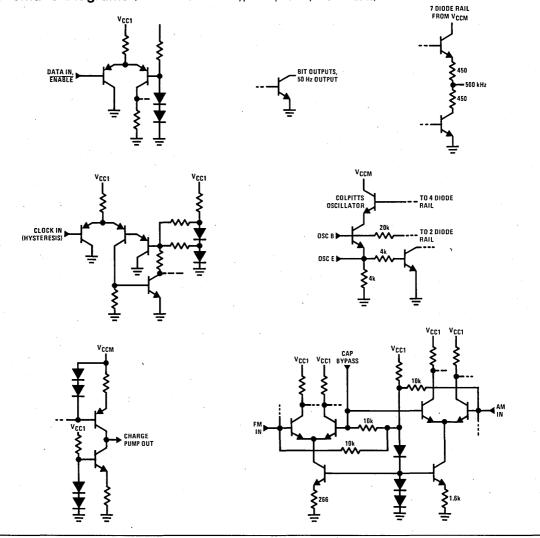
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
tCLKH	Minimum CLOCK High Pulse Width	,		275	550	ns
tCLKL	Minimum CLOCK Low Pulse Width			400	800	ns
tDS	Minimum DATA Setup Time, Minimum Time Before CLOCK that DATA Must be Valid			150	300	ns
<sup>†</sup> DH	Minimum DATA Hold Time, Minimum Time After CLOCK that DATA Must Remain Valid			400	800	ns

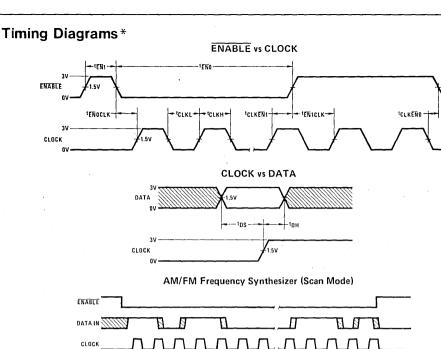
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

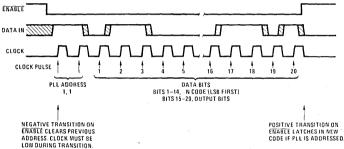
Note 2: Unless otherwise specified min/max limits apply across the 0°C to +70°C temperature range for the DS8906.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

#### Schematic Diagrams (DS8906 AM/FM PLL Typical Input/Output Schematics)







<sup>\*</sup>Timing diagrams are not drawn to scale. Scale within any one drawing may not be consistent, and intervals are defined positive as drawn.

#### **SERIAL DATA ENTRY INTO THE DS8906**

Serial information entry into the DS8906 is enabled by a low level on the ENABLE input. One binary bit is then accepted from the DATA input with each positive transition of the CLOCK input. The CLOCK input must be low for the specified time preceding and following the negative transition of the ENABLE input.

The first 2 bits accepted following the negative transition of the ENABLE input are interpreted as address. If these address bits are not 1,1, no further information will be accepted from the DATA inputs, and the internal data latches will not be changed when ENABLE returns high.

If these first 2 bits are 1,1, then all succeeding bits are accepted as data, and are shifted successively into the internal shift register as long as **ENABLE** remains low.

Any data bits preceding the 20th to last bit will be shifted out, and are thus irrelevant. Data bits are counted as any bits following 2 valid (1,1) address bits with the ENABLE low.

When the ENABLE input returns high, any further serial data input is inhibited. Upon this positive transition of the ENABLE, the data in the internal shift register is transferred into the internal data latches.

Note that until this time, the states of the internal data latches have remained unchanged.

These data bits are interpreted as follows:

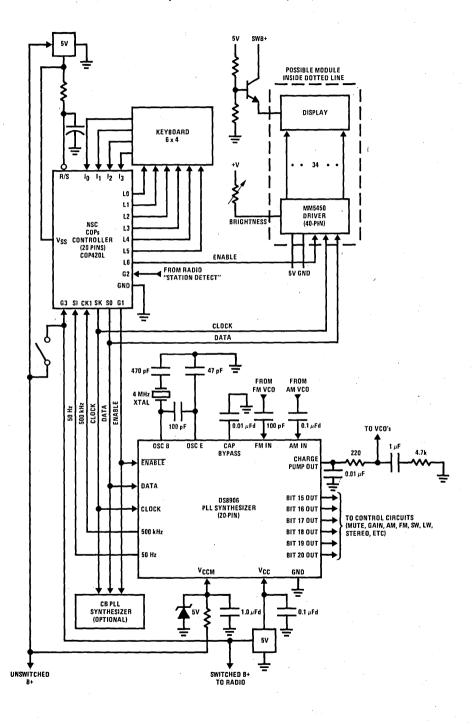
	· ·
ATA BIT POSITION	DATA INTERPRETATION
Last	Bit 20 Output (Pin 2)
2nd to Last	Bit 19 Output (Pin 1)
3rd to Last	Bit 18 Output (FM/AM) (Pin 20)
4th to Last	Bit 17 Output (Pin 19)
5th to Last	Bit 16 Output (Pin 18)
6th to Last	Bit 15 Output (Pin 17)
7th to Last	MSB of N (2 <sup>13</sup> )
8th to Last	(2 <sup>12</sup> )
9th to Last	(2 <sup>11</sup> )
10th to Last	(2 <sup>10</sup> )
11th to Last	(2 <sup>9</sup> )
12th to Last	(28)
13th to Last	(2 <sup>7</sup> )
14th to Last	(26) <b>&gt;</b> ÷N
15th to Last	(2 <sup>5</sup> )
16th to Last	(2 <sup>4</sup> )
17th to Last	(2 <sup>3</sup> )
18th to Last	(2 <sup>2</sup> )
19th to Last	$(2^1)$
20th to Last	LSB of N $(2^0)$

Note. The actual divide code is N+1, i.e., the number loaded plus 1.



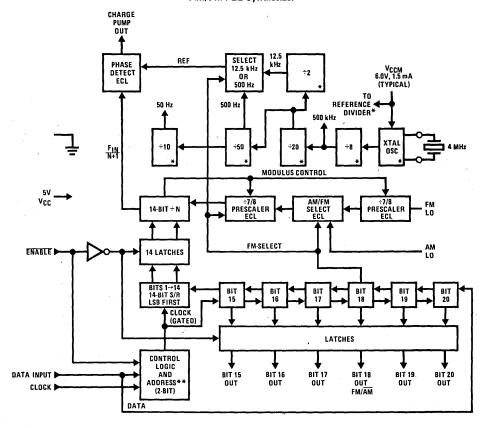
Typical Application Additional application notes are located at the back of section 11.

Electronically Tuned Radio Controller System; Direct Drive LED



## Logic Diagram

#### AM/FM PLL Synthesizer



<sup>\*</sup> Sections operating from V<sub>CCM</sub> supply
\*\* Address (1, 1)

# National Semiconductor

## **Frequency Synthesis**

## DS8907 AM/FM Digital Phase-Locked Loop Frequency Synthesizer

## **General Description**

The DS8907 is a PLL synthesizer designed specifically for use in AM/FM radios. It contains the reference oscillator, a phase comparator, a charge pump, a 120 MHz ECL/I<sup>2</sup>L dual modulus programmable divider, and an 18-bit shift register/latch for serial data entry. The device is designed to operate with a serial data controller generating the necessary division codes for each frequency, and logic state information for radio function inputs/outputs.

The Colpitts reference oscillator for the PLL operates at 4 MHz. A chain of dividers is used to generate a 500 kHz clock signal for the external controller. Additional dividers generate a 25 kHz reference signal for FM and a 10 kHz reference signal for AM. One of these reference signals is selected by the data from the controller for use by the phase comparator.

Data is transferred between the frequency synthesizer and the controller via a 3 wire bus system. This consists of a data input line, an enable line, and a clock line. When the enable line is low, data can be shifted from the controller into the frequency synthesizer. When the enable line is transitioned from low to high, data entry is disabled and data present in the shift register is latched.

From the controller 20-bit data stream, the first 2 bits address the device permitting other devices to share the same bus. Of the remaining 18-bit data word, the next 13 bits are used for the PLL divide code. The remaining 5 bits are connected via latches to output pins. These 5 bits can be used to drive radio functions such as gain, mute, FM, AM and stereo only. These outputs are open collector. Bit 16 is used internally to select the AM or FM local oscillator input and to select between the 10 kHz and 25 kHz reference. A high level at bit 16 indicates FM and a low level indicates AM.

The PLL consists of a 13-bit programmable I<sup>2</sup>L divider, an ECL phase comparator, an ECL dual modulus (p/p+1) prescaler, and a high speed charge pump. The programmable divider divides by (N+1), N being the number loaded into the shift register (bits 1-13 after address). It is clocked by the AM input via an ECL ÷ 7/8 prescaler, or through a ÷ 63/64 prescaler from the FM input. The AM input will work at frequencies up to 15 MHz, while the FM input works up to 120 MHz. The AM band is tuned with a frequency resolution of 10 kHz and the FM band is tuned with a resolution of 25 kHz. The buffered AM and FM inputs are self biased and can be driven directly by the VCO through a capacitor. The ECL phase comparator produces very accurate resolution of the phase difference between the input signal and the reference oscillator. The high speed charge pump consists of a switchable constant

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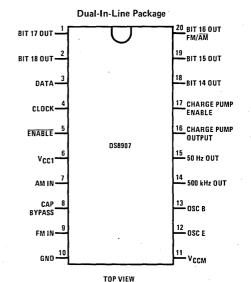
current source (-0.3 mA) and a switchable constant current sink (+0.3 mA). If the VCO frequency is low, the charge pump will source current, and sink current if the VCO frequency is high. When using an AFC the charge pump output may be forced into TRI-STATE® by applying a low level to the charge pump enable input.

A separate V<sub>CCM</sub> pin (typically drawing 1.5 mA) powers the oscillator and reference chain to provide controller clocking frequencies when the balance of the PLL is powered down.

#### **Features**

- Uses inexpensive 4 MHz reference crystal
- FIN capability greater than 120 MHz allows direct synthesis at FM frequencies
- FM resolution of 25 kHz allows usage of 10.7 MHz ceramic filter distribution
- Serial data entry for simplified control
- 50 Hz output for "time-of-day" reference driven from separate low power V<sub>CCM</sub>
- 5-open collector buffered outputs for controlling various radio functions
- Separate AM and FM inputs. AM input has 15 mV (typical) hysteresis

## **Connection Diagram**



Order Number DS8907N See NS Package N20A

bsolute Maximum Ratings (Note 1)		Operating Cond			
			MIN	MAX	UNITS
Supply Voltage		Supply Voltage, VCC			
(V <sub>CC1</sub> )	7V	V <sub>CC1</sub>	4.75	5.25	V
(V <sub>CCM</sub> )	7 <b>V</b>	VCCM	4.5	6.0	V
Input Voltage	7V	Temperature, TA	0	70	°C
Output Voltage	. 7V				
Storage Temperature Range	-65°C to +150°C				
Lead Temperature (Soldering, 10 seconds)	300°C				

## DC Electrical Characteristics (Notes 2 and 3)

	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
VIH	Logical "1" Input Voltage			2.1			V
ŀін	Logical "1" Input Current	V <sub>IN</sub> = 2.7V			0	10	μΑ
VIL	Logical "0" Input Voltage					0.7	V
IIL	Logical "O" Input Current	Data, Clock, and ENABLE Inputs	, V <sub>IN</sub> = 0V		-5	-25	μΑ
IIL .	Logical "0" Input Current	Charge Pump Enable, V <sub>IN</sub> = 0V			-250	-450	μΑ
ЮН	Logical "1" Output Current All Bit Outputs, 50 Hz Output 500 kHz Output	V <sub>OH</sub> = 5.25V V <sub>OH</sub> = 2.4V, V <sub>CCM</sub> = 4.5V				50 -250	μ <b>Α</b> μ <b>Α</b>
VOL	Logical "0" Output Voltage All Bit Outputs  50 Hz Output, 500 kHz Output	I <sub>OL</sub> = 5 mA I <sub>OL</sub> = 250 μA				0.5	V
¹CC1	Supply Current (V <sub>CC1</sub> )	All Bit Outputs High		. ,	90	160	mA
ICCM(STANDBY	VCCM Supply Current	V <sub>CCM</sub> = 6.0V, All Other Pins Ope	en .		1.5	4.0	mA
lout	Charge Pump Output Current	1.2V ≤ V <sub>OUT</sub> ≤ V <sub>CCM</sub> - 1.2V	Pump Up	-0.10	-0.30	-0.6	mA
		V <sub>CCM</sub> ≤6.0V	Pump Down	0.10	0.30	0.6	mA
	<b>.</b>		TRI-STATE®		0	±100	nA
CCM(OPERATE)	VCCM Supply Current	V <sub>CCM</sub> = 6.0V, V <sub>CC1</sub> = 5.25V, All Other Pins Open			2.5	6.0	mA

## AC Electrical Characteristics $\,\,V_{CC}$ = 5V, $\,T_A$ = 25°C, $\,t_r \leq 10$ ns, $\,t_f \leq 10$ ns

-	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
VIN(MIN)(F)	F <sub>IN</sub> Minimum Signal Input	AM and FM Inputs, $0^{\circ}C \le T_A \le$	70°C		20	100	mV (rms)
V <sub>IN(MAX)(F)</sub>	FIN Maximum Signal Input	AM and FM Inputs, $0^{\circ}C \le T_A \le$	70°C	1000	1500		mV (rms)
FOPERATE	Operating Frequency Range	V <sub>IN</sub> = 100 mV rms	AM	0.4	2	8	MHz
	(Sine Wave Input)	0°C ≤ T <sub>A</sub> ≤ 70°C	FM	60		120	MHz
R <sub>IN</sub> (FM)	AC Input Resistance, FM	120 MHz, V <sub>IN</sub> = 100 mV rms		300			Ω
RIN (AM)	AC Input Resistance, AM	2 MHz, V <sub>IN</sub> = 100 mV rms		1000			Ω
CIN	Input Capacitance, FM and AM	V <sub>IN</sub> = 120 MHz		3	6.	10	pF
tEN1	Minimum ENABLE High Pulse Width				625	1250	ns
tEN0	Minimum ENABLE Low Pulse Width				375	750	ns
tCLKEN0	Minimum Time Before ENABLE Goes Low that CLOCK Must be Low				-50	0	ns
tENOCLK	Minimum Time After ENABLE Goes Low that CLOCK Must Remain Low				275	550	ns
tCLKEN1	Minimum Time Before ENABLE Goes High that Last Positive CLOCK Edge May Occur	·			300	600	ns

## AC Electrical Characteristics (Continued) $V_{CC}$ = 5V, $T_A$ = 25°C, $t_r \le 10$ ns, $t_f \le 10$ ns

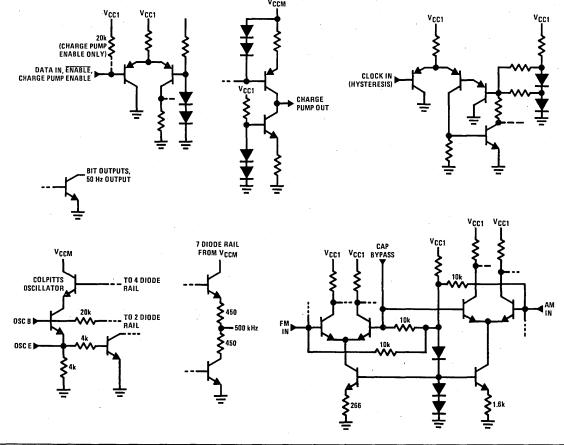
	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
<sup>t</sup> EN1CLK	Minimum Time After ENABLE Goes High Before an Unused Positive CLOCK Edge May Occur			175	350	ns
tCLKH '	Minimum CLOCK High Pulse Width			275	550	ns
<sup>†</sup> CLKL	Minimum CLOCK Low Pulse Width			400	800	ns
tDS	Minimum DATA Setup Time, Minimum Time Before CLOCK that DATA Must be Valid			150	300	ns
<sup>†</sup> DH	Minimum DATA Hold Time, Minimum Time After CLOCK that DATA Must Remain Valid			400	800	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -40°C to +85°C temperature range for the DS8907.

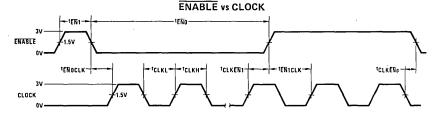
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

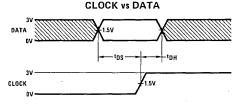
## Schematic Diagrams (DS8907 AM/FM PLL Typical Input/Output Schematics)



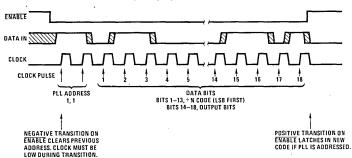








#### AM/FM Frequency Synthesizer (Scan Mode)



<sup>\*</sup>Timing diagrams are not drawn to scale. Scale within any one drawing may not be consistent, and intervals are defined positive as drawn.

#### **SERIAL DATA ENTRY INTO THE DS8907**

Serial information entry into the DS8907 is enabled by a low level on the  $\overline{\text{ENABLE}}$  input. One binary bit is then accepted from the DATA input with each positive transition of the CLOCK input. The CLOCK input must be low for the specified time preceding and following the negative transition of the  $\overline{\text{ENABLE}}$  input.

The first two bits accepted following the negative transition of the ENABLE input are interpreted as address. If these address bits are not 1,1, no further information will be accepted from the DATA inputs, and the internal data latches will not be changed when ENABLE returns high.

If these first two bits are 1,1, then all succeeding bits are accepted as data, and are shifted successively into the internal shift register as long as ENABLE remains low.

Any data bits preceding the 18th to last bit will be shifted out, and thus are irrelevent. Data bits are counted as any bits following two valid address bits (1,1) with the ENABLE low, When the ENABLE input returns high, any further serial data entry is inhibited. Upon this positive transition, the data in

the internal shift register is transferred into the internal data latches. Note that until this time, the states of the internal data latches have remained unchanged.

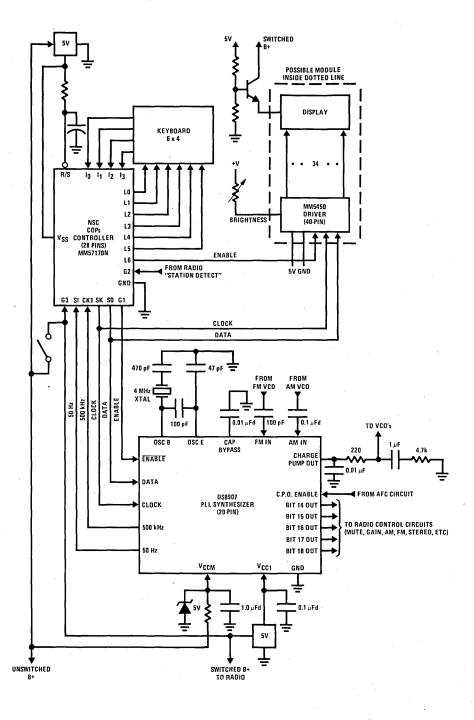
These data bits are interpreted as follows:

DATA BIT POSITION	DATA INTERP	RETATION
Last	Bit 18 Output (Pin	2)
2nd to Last	Bit 17 Output (Pin-	1)
3rd to Last	Bit 16 Output (FM	/AM) (Pin 20)
4th to Last	Bit 15 Output (Pin	19)
5th to Last	Bit 14 Output (Pin	18)
6th to Last	MSB of ÷N (2 <sup>12</sup> )	
7th to Last	(2 <sup>11</sup> )	
8th to Last	(2 <sup>10</sup> )	
9th to Last	(2 <sup>9</sup> )	
10th to Last	(2 <sup>8</sup> )	
11th to Last	$(2^{7})$	
12th to Last	(2 <sup>6</sup> )	<b>&gt;</b> ÷N
13th to Last	(2 <sup>5</sup> )	
14th to Last	(2 <sup>4</sup> )	
15th to Last	(2 <sup>3</sup> )	
16th to Last	(2 <sup>2</sup> )	
17th to Last	(2 <sup>1</sup> )	
18th to Last	LSB of $\div$ N (2 <sup>0</sup> )	I

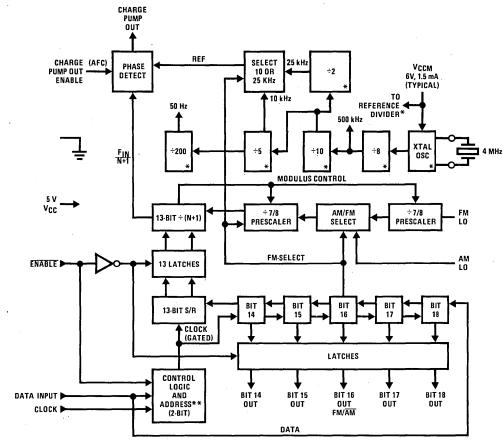
Note. The actual divide code is N+1, ie., the number loaded plus 1.

## Typical Application Additional application notes are located at the back of section 11.

Electronically Tuned Radio Controller System; Direct Drive LED



#### AM/FM PLL/Synthesizer (Serial Data 20-Pin Package)



<sup>\*</sup> Sections operating from V<sub>CCM</sub> supply.

<sup>\*\*</sup> Address (1, 1)

# National Semiconductor

## **Frequency Synthesis**

## DS8908 AM/FM Digital Phase-Locked Loop Frequency Synthesizer

#### **General Description**

The DS8908 is a PLL synthesizer designed specifically for use in AM/FM radios. It contains the reference oscillator, a phase comparator, a charge pump, an operational amplifier, a 120 MHz ECL/I<sup>2</sup>L dual modulus programmable divider, and a 19-bit shift register/latch for serial data entry. The device is designed to operate with a serial data controller generating the necessary division codes for each frequency, and logic state information for radio function inputs/outputs.

A 3.96 MHz pierce oscillator and divider chain generate a 1.98 MHz external controller clock, a 20 kHz, 10 kHz, 9 kHz, and 1 kHz reference signals, and a 50 Hz time-of-day signal. The oscillator and divider chain are sourced by the  $V_{CCM}$  pin thus providing a low power controller clock drive and time-of-day indication when the balance of the PLL is powered down.

The 21-bit serial data stream is transferred between the frequency synthesizer and the controller via a 3-wire bus system comprised of a data line, a clock line, and an enable line.

The first 2 bits in the serial data stream address the synthesizer thus permitting other devices such as display drivers to share the same bus. The next 14 bits are used for the PLL (N + 1) divide code. The 15th bit is used internally to select the AM or FM local oscillator input. A high level on this bit enables the FM input and a low level enables the AM input. The 16th and 17th bits are used to select one of the 4 reference frequencies. The 18th and 19th bits are connected via latches to open collector outputs. These outputs can be used to drive radio functions such as gain, mute, AM, FM, or charge pump current source levels.

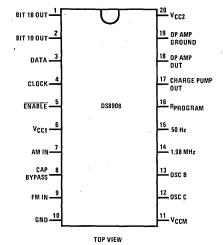
The PLL consists of a 14-bit programmable I<sup>2</sup>L divider, an ECL phase comparator, an ECL dual modulus (p/p + 1) prescaler, a high speed charge pump, and an operational amplifier. The programmable divider divides by (N + 1), N being the number loaded into the shift register. The programmable divider is clocked through a  $\div$  7/8 prescaler by the AM input or through a  $\pm 63/64$  prescaler by the FM input. The AM input will work at frequencies up to 15 MHz, while the FM input works up to 120 MHz. The VCO can be tuned with a frequency resolution of either 1 kHz, 9 kHz, 10 kHz, or 20 kHz. The buffered AM and FM inputs are self-biased and can be driven directly by the VCO through a capacitor. The ECL phase comparator produces very accurate resolution of the phase difference between the input signal and the reference oscillator. The high speed charge pump consists of a switchable constant current source and sink. The charge pump can be programmed to deliver from 75  $\mu$ A to 750  $\mu$ A of constant current by connection of an external resistor from pin R<sub>PROGRAM</sub> to ground or the open collector bit outputs. Connection of programming resistors to the bit outputs enables the controller to adjust the loop gain for the particular reference frequency selected. The charge pump will source current if the VCO frequency is high and sink current if the VCO frequency is low. The low noise operational amplifier provided has a high impedance JFET input and a large output voltage range. The op amp's negative input is common with the charge pump output and its positive input is internally biased.

#### **Features**

- Uses inexpensive 3.96 MHz reference crystal
- F<sub>IN</sub> capability greater than 120 MHz allows direct synthesis at FM frequencies
- FM resolution of either 10 kHz or 20 kHz allows usage of 10.7 MHz ceramic filter distribution
- Serial data entry for simplified control
- 50 Hz output for time-of-day reference driven from separate low power V<sub>CCM</sub>
- 2 open collector buffered outputs for controlling various radio functions or loop gain
- Separate AM and FM inputs; AM input has 15 mV (typical) hysteresis
- Programmable charge pump current sources enable adjustment of system loop gain
- Operational amplifier provides high impedance load to charge pump output and a wide voltage range for the VCO input

## **Connection Diagram**

#### **Dual-In-Line Package**



Order Number DS8908N See NS Package N20A

Absolute Maximum Ratings (Note 1)		Operating Co			
			Min	Max	Units
Supply Voltage		V <sub>CC1</sub>	4.5	5.5	٧
(V <sub>CC1</sub> )(V <sub>CCM</sub> )	7V	V <sub>CC2</sub>	V <sub>CC1</sub> + 1.5	15.0	٧
(V <sub>CC2</sub> )	17V	V <sub>CCM</sub>	3.5	5.5	٧
Input Voltage	7V	Temperature, T <sub>△</sub>	-40	+85	°C
Output Voltage	· 7V	, , ,			
Storage Temperature Range	-65°C to +150°C			•	
Lead Temperature (Soldering, 10 seconds)	300°C				

## DC Electrical Characteristics (Notes 2 and 3)

Parameter		Conditions		Min	Тур	Max	Units
V <sub>IH</sub>	Logical "1" Input Voltage			2.0			٧
I <sub>IH</sub>	Logical "1" Input Current	V <sub>IN</sub> = 2.7V			0	10	μΑ
V <sub>IL</sub>	Logical "0" Input Voltage					0.8	٧
IIL	Logical "0" Input Current	Data, Clock, and ENABLE	Inputs, V <sub>IN</sub> = 0V		-5	-25	μΑ
Гон	Logical "1" Output Current All Bit Outputs, 50 Hz Output 1.98 MHz Output	V <sub>OH</sub> = 5.5V V <sub>OH</sub> = 2.4V, V <sub>CCM</sub> = 4.5V			50 -250	μ <b>Α</b> μ <b>Α</b>	
V <sub>OL</sub>	Logical "0" Output Voltage All Bit Outputs 50 Hz Output, 1.98 MHz Output	<sub>OL</sub> = 5 mA <sub>OL</sub> = 250 μA				0.5 0.5	V V
	1.98 MHz Output	$I_{OL} = 20 \mu A, T_A > 70^{\circ} C$ $I_{OL} = 20 \mu A, T_A \le 70^{\circ} C$			0.3 0.4	V	
I <sub>CC1</sub>	Supply Current (V <sub>CC1</sub> )	All Bit Outputs High				160	mA
ССМ	V <sub>CCM</sub> Supply Current	V <sub>CCM</sub> = 5.5V, All Other Pins	Open		2.5	4.0	mA
lout	Charge Pump Output Current	$3.33k \le R_{PROG} \le 33.3k$	Pump Up	- 20	I <sub>PROG</sub>	+ 20	%
		I <sub>OUT</sub> Measured Between	Pump Down	- 20	IPROG	+ 20	%
		Pin 17 and Pin 18 I <sub>PROG</sub> = V <sub>CC1</sub> /2 R <sub>PROG</sub>	TRI-STATE®		0	± 250	nA
I <sub>CC2</sub>	V <sub>CC2</sub> Supply Current	V <sub>CCM</sub> = 5V, V <sub>CC1</sub> = 5.5V, V <sub>C</sub> All Other Pins Open	<sub>02</sub> = 15V		6.7	11	mA
OP <sub>VOH</sub>	Op Amp Minimum High Level	$V_{CC1} = 4.5V$ , $I_{OH} = -750 \mu$	A	V <sub>CC2</sub> - 0.4			٧
OP <sub>VOL</sub>	Op Amp Maximum Low Level	V <sub>CC1</sub> = 5.5V, I <sub>OL</sub> = 750 μA				0.6	٧
CPOBIAS	Charge Pump Bias Voltage Delta	CPO Shorted to Op Amp Output CPO = TRI-STATE Op Amp I <sub>OL</sub> : 750 μA vs = 750 μA				100	mV

## AC Electrical Characteristics $V_{CC} = 5V$ , $T_A = 25$ °C, $t_r \le 10$ ns, $t_f \le 10$ ns

Parameter		Con	Min	Тур	Max	Units	
V <sub>IN(MIN)(F)</sub>	F <sub>IN</sub> Minimum Signal Input	AM and FM Inputs,		20	100	mV(rms)	
V <sub>IN(MAX)(F)</sub>	F <sub>IN</sub> Maximum Signal Input	AM and FM Inputs,	1000	1500		mV(rms)	
F <sub>OPERATE</sub>	Operating Frequency Range (Sine Wave Input)	V <sub>IN</sub> = 100 mV rms -40°C≤T <sub>A</sub> ≤85°C	0.5 80		15 120	MHz MHz	
R <sub>IN</sub> (FM)	AC Input Resistance, FM	120 MHz, V <sub>IN</sub> = 100 r	nV rms	600			Ω
R <sub>IN</sub> (AM)	AC Input Resistance, AM	15 MHz, V <sub>IN</sub> = 100 m	V rms	1000			Ω
C <sub>IN</sub>	Input Capacitance, FM and AM	V <sub>IN</sub> = 120 MHz (FM),	15 MHz (AM)	3	6	10	pF
t <sub>EN1</sub>	Minimum ENABLE High Pulse Width	,			625	1250	ns

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## **AC Electrical Characteristics** (Continued) $V_{CC} = 5V$ , $T_A = 25$ °C, $t_f \le 10$ ns, $t_f \le 10$ ns

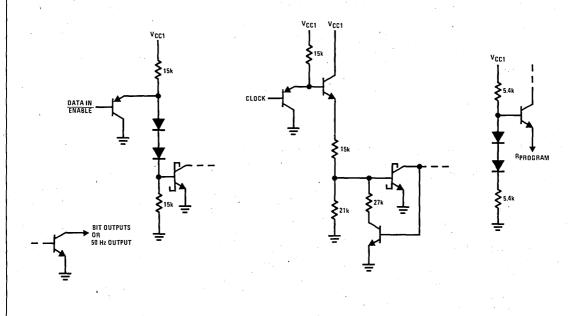
	Parameter	Conditions	Min	Тур	Max	Units
t <sub>EN0</sub>	Minimum ENABLE Low Pulse Width			375	750	ns
t <sub>CLKEN0</sub>	Minimum Time Before ENABLE Goes Low that CLOCK Must be Low			-50	0	ns
t <sub>ENOCLK</sub>	Minimum Time After ENABLE Goes Low that CLOCK Must Remain Low			275	550	ns
t <sub>CLKEN1</sub>	, Minimum Time Before ENABLE Goes High that Last Positive CLOCK Edge May Occur			300	600	ns
t <sub>EN1CLK</sub>	Minimum Time After ENABLE Goes High Before an Unused Positive CLOCK Edge May Occur			175	350	ns
t <sub>CLKH</sub>	Minimum CLOCK High Pulse Width			275	550	ns
t <sub>CLKL</sub>	Minimum CLOCK Low Pulse Width			400	800	ns
t <sub>DS</sub>	Minimum DATA Set-Up Time, Minimum Time Before CLOCK that DATA Must be Valid			150	300	ns
t <sub>DH</sub>	Minimum DATA Hold Time, Minimum Time After CLOCK that DATA Must Remain Valid			400	800	ns

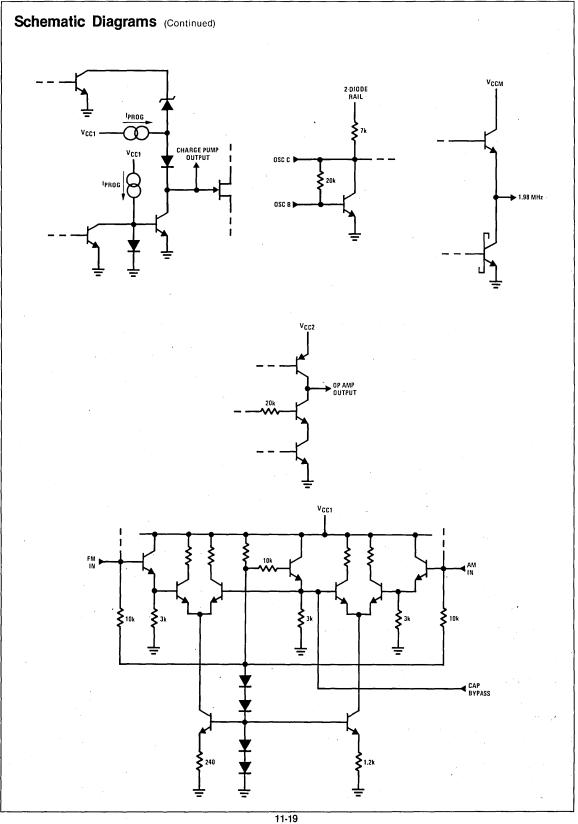
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -40°C to +85°C temperature range for the DS8908.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

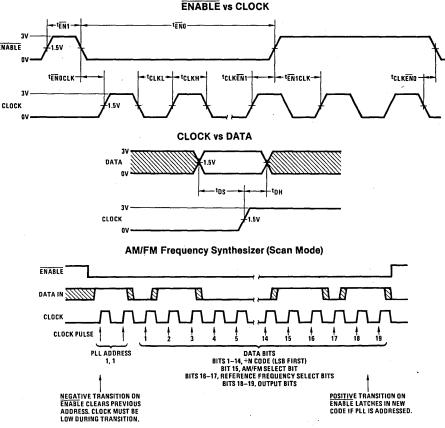
## Schematic Diagrams (DS8908 AM/FM PLL Typical Input/Output Schematics)





### Timing Diagrams\*

ENABLE



<sup>\*</sup>Timing diagrams are not drawn to scale. Scale within any one drawing may not be consistent, and intervals are defined positive as drawn.

#### Serial Data Entry into the DS8908

Serial information entry into the DS8908 is enabled by a low level on the ENABLE input. One binary bit is then accepted from the DATA input with each positive transition of the CLOCK input. The CLOCK input must be low for the specified time preceding and following the negative transition of the ENABLE input.

The first two bits accepted following the negative transition of the ENABLE input are interpreted as address. If these address bits are not 1,1, no further information will be accepted from the DATA inputs, and the internal data latches will not be changed when ENABLE returns high.

If these first two bits are 1,1, then all succeeding bits are accepted as data, and are shifted successively into the internal shift register as long as ENABLE remains low.

Any data bits preceding the 19th to last bit will be shifted out, and thus are irrelevant. Data bits are counted as any bits following two valid address bits (1,1) with the ENABLE low. When the ENABLE input returns high, any further serial data entry is inhibited. Upon this positive transition, the data in the internal shift register is transferred into the internal data latches. Note that until this time, the states of the internal data latches have remained unchanged.

These data bits are interpreted as follows:

<b>Data Bit Position</b>	Data Interpretation
Last	Bit 19 Output (Pin 2)
2nd to Last	Bit 18 Output (Pin 1)
3rd to Last	Ref. Freq. Select Bit <sup>(1)</sup> 17
4th to Last	Ref. Freq. Select Bit <sup>(1)</sup> 16
5th to Last	AM/FM Select Bit 15
6th to Last	(2 <sup>13</sup> )
7th to Last	(2 <sup>12</sup> )
8th to Last	(2 <sup>11</sup> )
9th to Last	(2 <sup>10</sup> )
10th to Last	(2 <sup>9</sup> )
11th to Last	(2 <sup>8</sup> )
12th to Last	$(2^7) \qquad \div N^{(2)}$
13th to Last	(2 <sup>6</sup> )
14th to Last	(2 <sup>5</sup> )
15th to Last	(2 <sup>4</sup> )
16th to Last	. (2 <sup>3</sup> )
17th to Last	(2 <sup>2</sup> )
18th to Last	(2 <sup>1</sup> )
19th to Last	LSB of ÷N (2 <sup>0</sup> )
	•

Note 1: See Reference Frequency Select Truth Table.

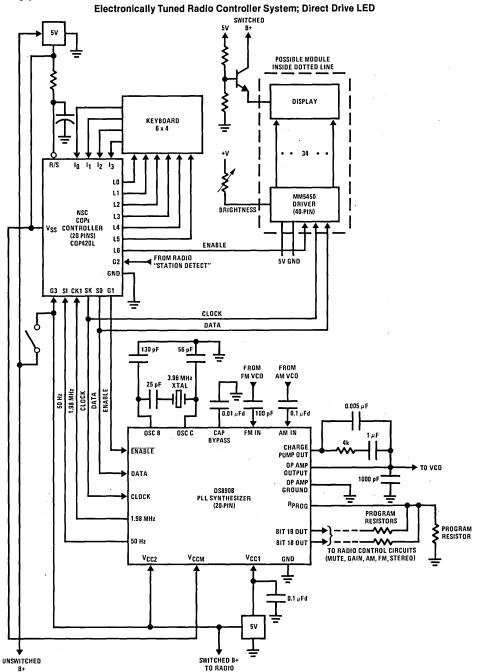
Note 2: The actual divide code is N + 1, ie., the number loaded plus 1.

### **Truth Table**

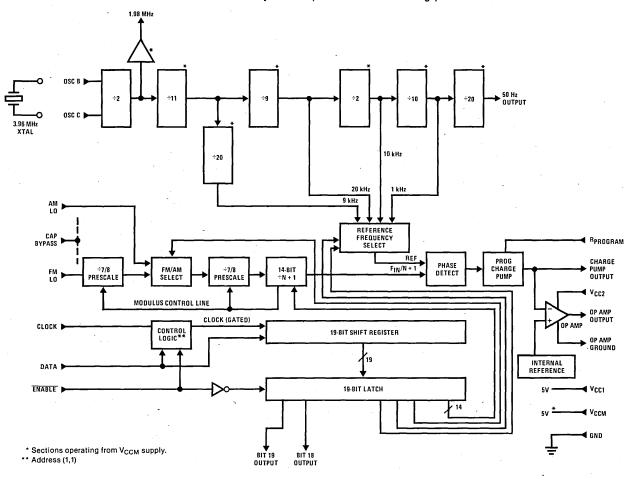
#### REFERENCE FREQUENCY SELECTION TRUTH TABLE

Seria	l Data	Reference Frequency
Bit 16	Bit 17	(kHz)
1	1	20
. 1	0	10
0	1	9
0	0	1

Typical Application Additional application notes are located at the back of section 11.



#### AM/FM PLL/Synthesizer (Serial Data 20-Pin Package)





## DS8614, DS8615, DS8616, DS8617 130/225 MHz Low Power **Dual Modulus Prescalers**

## **General Description**

The DS8614 series products are low power dual modulus prescalers which divide by 20/21, 32/33, 40/41, and 64/65, respectively. The modulus control (MC) input selects division by N when at a high TTL level and division by N+1 when at a low TTL level. The clock inputs are buffered, providing 40 mVrms input sensitivity. The two outputs provide the user the option to wire either a totem-pole or opencollector output structure. Additionally, the user can wire a resistor between the two output pins to minimize edge transition emissions. The outputs are designed to drive positive edge triggered PLLs. These products can be operated from either an unregulated 6.8V to 13.5V source or regulated  $5V \pm 10\%$  source. Unregulated operation is obtained by connecting V<sub>S</sub> to the source with V<sub>REG</sub> open. Regulated operation is obtained by connecting both V<sub>S</sub> and V<sub>REG</sub> to the supply source.

The device can be used in phase-locked loop applications such as FM radio or other communications bands to prescale the input frequency down to a more usable level. A digital frequency display system can also be derived separately or in conjunction with a phase-locked loop, and it can extend the useful range of many inexpensive frequency counters to 225 MHz.

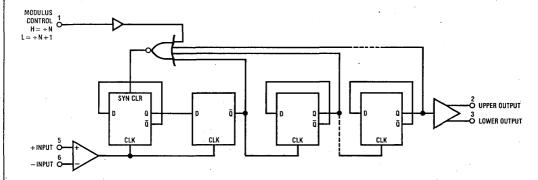
**Frequency Synthesis** 

#### **Features**

- Input frequency: 130 MHz (-4, -3); 225 MHz (-2, std)
- Low power: 10 mA (-4, -2); 7 mA (-3, std)
- Input sensitivity: 100 mVrms (-4, -3); 40 mVrms (-2, std)
- Pin compatible with Motorola MC12015-17 prescalers
- Unregulated/regulated power supply option

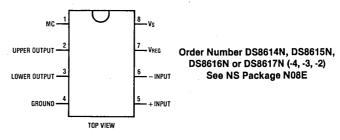


#### Generalized + N/N + 1



## **Connection Diagram**

#### **Dual-In-Line Package**



## Absolute Maximum Ratings (Note 1)

V <sub>S</sub> , Unregulated Supply Voltage	. 15V
V <sub>REG</sub> , Regulated Supply Voltage	7V
Modulus Control Input Voltage	7V
Open-Collector Output Voltage	7V
Operating Free Air Temperature Range	-30°C to +70°C
Storage Temperature Range	-65°C to $+150$ °C

## **Recommended Operating Conditions**

Symbol	Symbol	Parameter	Conditions	DS8614-4 DS8615-4 DS8616-4 DS8617-4		DS8614-3 DS8615-3 DS8616-3 DS8617-3		DS8615-3 DS8 DS8616-3 DS8		DS:	8614 8615 8616 8617	Units
			Min	Max	Min	Max	Min	Max	Min	Max	1	
٧s	Unregulated Supply Voltage	V <sub>REG</sub> = Open	6.8	13.5	6.8	13.5	6.8	13.5	5.5	13.5	V	
VREG	Regulated Supply Voltage	V <sub>S</sub> and V <sub>REG</sub> Shorted	4.5	5.5	4.5	5.5	4.5	5.5	4.5	5.5	V	
fMAX	Toggle Frequency	V <sub>IN</sub> = 100 mVrms	20	130	20	130		225		225	MHz	
VIN	Input Signal Amplitude		100	300	100	300	40	300	40	300	mVrms	
V <sub>SLW</sub>	Slew Rate		20		20		20		20		V/μs	
Іон	High Level Output Current			- 400		- 400		- 400		- 400	μА	
lOL	Low Level Output Current			2.0		2.0		2.0		2.0	mA	

## DC Electrical Characteristics (Notes 2 and 3)

Symbol	Parameter	Conditions	DS86	DS8614-4 DS8615-4 DS8616-4 DS8617-4		DS8614-3 DS8615-3 DS8616-3 DS8617-3		14-2 15-2 16-2 17-2	DS8615 DS8616		Units
			Min	Max	Min	Max	Min	Max	Min	Max	
VIH	High Level MC Input Voltage	V <sub>S</sub> = 13.5V, V <sub>REG</sub> = Open	2.0	•	2.0		2.0		2.0		V
VIL	Low Level MC Input Voltage	V <sub>REG</sub> = V <sub>S</sub> = 4.5V		0.8		0.8		0.8		0.8	٧
VOH	High Level Output Voltage	I <sub>OH</sub> = -0.4 mA, Pins 2 and 3 Shorted	V <sub>REG</sub> - 2		V <sub>REG</sub> -2		V <sub>REG</sub> -2		V <sub>REG</sub> -2		V
CEX	Open-Collector High Level Output	Lower Output = 5.5V		100		100		100		100	μА
V <sub>OL</sub>	Low Level Output Voltage	V <sub>REG</sub> = 4.5V, I <sub>OL</sub> = 2 mA		0.5		0.5		0.5		0.5	٧
11	Max MC Input Current	V <sub>S</sub> = 13.5V, V <sub>REG</sub> = Open, V <sub>IH</sub> = 7V		100		100	,	100		100	μА
-I <sub>IH</sub>	High Level MC Input Current	V <sub>REG</sub> = 4.5V, V <sub>IH</sub> = 2.7V		20		20		20		20	μА
IIL	Low Level MC Input Current	V <sub>S</sub> = 13.5V, V <sub>REG</sub> = Open, V <sub>IL</sub> = 0.4V		- 200		- 100		- 200		- 100	μА
IS	Supply Current, Unregulated Mode	V <sub>S</sub> = 13.5V, V <sub>REG</sub> = Open		10		7		10		7	mA
REG	Supply Current, Regulated Mode	V <sub>S</sub> = V <sub>REG</sub> = 5.5V		10		7		10		7	mA

## AC Electrical Characteristics $V_{CC} = 5V \pm 10\%$ , $T_A = -30$ °C to 70°C

Symbol	Parame	ter	Conditions	Min	Max	Units
tMODULUS	Modulus Set-Up Time	DS8614			55	
	(Notes 4 and 5)	DS8615, DS8616			65	ns
		DS8617			75	
R <sub>IN</sub>	AC Input Resistance		V <sub>IN</sub> = 100 MHz and 50 mVrms	1.0		kΩ
C <sub>IN</sub>	Input Capacitance		V <sub>IN</sub> = 100 MHz and 50 mVrms	. 3	10	pF

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

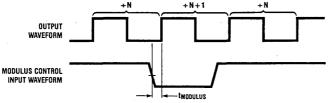
Note 2: Unless otherwise specified min/max limits apply across the -30°C to +70°C temperature range.

Note 3: All currents into device pins are shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: tmodulus = the period of time the modulus control level must be defined prior to the positive transition of the prescaler output to ensure proper modulus selection.

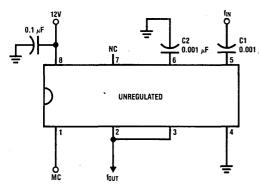
Note 5: See Timing Diagrams.

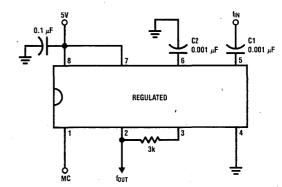
## Timing Diagram



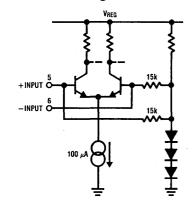
The logic state of the modulus control input just prior to the output's rising edge will determine the modulus ratio of the device immediately following that rising edge. The pulse width difference of N and N + 1 operation occurs during the output = HI condition.

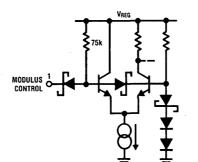
## **Typical Applications**

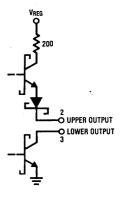




## **Schematic Diagrams**







## **Application Hints**

#### **OPERATING NOTES**

The signal source is usually capacitively coupled to the input. At higher frequencies a  $0.001\,\mu\text{F}$  input capacitor (C1) is usually sufficient, with larger values used at the lower frequencies. If the input signal is likely to be interrupted, it may be desirable to connect a  $100\,k\Omega$  resistor between one input and ground to stabilize the device. In the single-ended mode, it is preferable to connect the resistor to the unused input. In the differential mode, the resistor can be connected to either input. The addition of the  $100\,k\Omega$  pull-down resistor causes a loss of input sensitivity, but prevents circuit oscillations under no signal (open circuit) conditions. In addition, in the single ended mode, a capacitor of  $0.001\,\mu\text{F}$  (C2) should be connected between the

unused input and the ground plane to provide a good high frequency bypass. The capacitor should be made larger for lower frequencies.

The input waveform may be sinusoidal, but below about 20 MHz the operation of the circuit becomes dependent on the slew rate of the input rather than amplitude. A square wave input with a slew rate of greater than 20V/µs will permit correct operation down to lower frequencies, provided the proper input coupling capacitor is provided.

For regulated mode operation connect V<sub>S</sub> to V<sub>REG</sub> to ensure proper operation (see Typical Application diagram).

## DS8626 120 MHz Divide-by-40 Prescaler DS8629 120 MHz Divide-by-100 Prescaler

## **General Description**

The DS8626 and DS8629 are fixed ratio counters combining ECL and Low Power Schottky technology on a single monolithic substrate. Both provide high frequency capability and TTL compatibility. A single 5.2V ±10% supply is needed.

The device can be operated in a single-ended or differential input mode, with the signal source typically capacitively coupled to the input. An input amplifier is included to allow use of extremely small amplitude, high frequency signals. The output of the device is a square wave of frequency four = fIN/100 for the DS8629 and fOUT = fIN/40 for the DS8626. The output is standard Low Power Schottky.

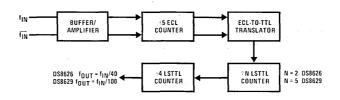
#### **Features**

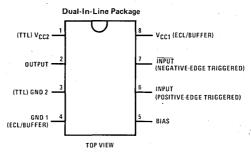
■ High frequency, dc-120 MHz-small input amplitude

**Frequency Synthesis** 

- Sine wave input 30 MHz < f<sub>IN</sub> < 120 MHz
- TTL compatible output
- May be used with TTL input
- Single supply operation 5.2V ±10%
- Single ended or differential input modes
- Positive or negative-edge triggered
- Count down sequence avoids broadcast FM IF harmonics

## **Logic and Connection Diagrams**

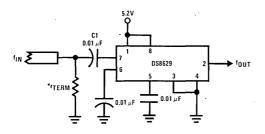




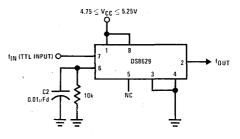
Order Number DS8626N or DS8629N See NS Package N08A

## **Typical Applications**

High Frequency-Single-Ended Input



TTL Input-dc  $< f_{IN} < f_{MAX}$ 



<sup>\*</sup>rTERM is the termination impedance

## Absolute Maximum Ratings (Note 1)

## **Operating Conditions**

 Supply Voltage
 7V

 Input Voltage
 5V

 Output Voltage
 5.5V

 Storage Temperature Range
 -65° C to +150° C

 Lead Temperature (Soldering, 10 seconds)
 300° C

## Electrical Characteristics (Notes 2 and 3)

	PARAMETER	C	ONDITIONS	MIN	TYP	MAX	UNITS
VIN1(p-p)	Input Voltage (Peak-To- Peak)	Single-Ended	200		1000	mV	
V <sub>IN2(p-p)</sub>	Input Voltage (Peak-To- Peak)	Differential (	100		1000	mV	
fSINE	Input Frequency with Sine Wave	V1N = 600 m	30		120	MHz	
fTTL	Input Frequency with TTL Input		0		120	MHz	
dv	Minimum Slew Rate of Square Wave Input	V <sub>IN</sub> = 600 m			100	V/μs	
Voн	Logical "1" Output Voltage	V <sub>CC</sub> = Min,	OH = -10 μA OH = -400 μA OH = -1.6 mA	2.9 2.4 2.0			. V V
los	Output Short-Circuit Current	VCC = Max	,	-10		-40	mA
VOL	Logical "0" Output Voltage	V <sub>CC</sub> = Min				0.5 0.4	V V
Icc	Supply Current	V <sub>CC</sub> = Max	DS8629 DS8626		90 80	135 125	mA mA
Z <sub>IN</sub>	Input Impedance	V <sub>IN</sub> = 0.1 V <sub>I</sub> Freq. = 120 I	100	200	350	Ω	

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified, min/max limits apply across the  $0^{\circ}$ C to  $70^{\circ}$ C range for the DS8629 and DS8626. All typical values are for  $T_A = 25^{\circ}$ C and  $V_{CC} = 5.2V$ .

Note 3: All currents into device pins shown as positive, out of device pins negative, all voltage referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

#### **Application Hints**

#### **OPERATING NOTES**

Two ground and two V<sub>CC</sub> connections are provided separating the ECL and buffer/amplifier stages from the TTL section, isolating the noise transients inherent in the TTL structure. In most cases, shorting the two grounds externally to a good ground plane and the V<sub>CC</sub>'s to a wide V<sub>CC</sub> bus will provide sufficient isolation. All components used in the circuit layout should be suitable for the frequencies involved and leads should be kept short to minimize stray inductance. A well by-passed voltage source should be used.

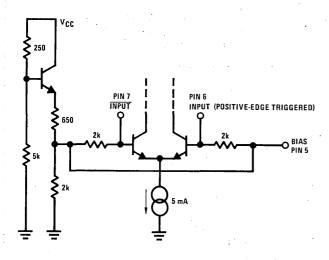
The signal source is usually capacitively coupled to the input. At higher frequencies a 0.01  $\mu F$  input capacitor (C1) is usually sufficient, with larger values used at the lower frequencies. If the input signal is likely to be interrupted, it may be desirable to connect a 100 k $\Omega$  resistor between one input and ground to stabilize the device. In the single-ended mode, it is preferable to connect the resistor to the unused input. In the differential mode, the resistor can be connected to either input. The addition of the 100 k $\Omega$  pull-down resistor causes a loss of input sensitivity, but prevents circuit oscillations under no signal (open circuit) conditions. In addition, in the single ended mode, a capacitor of 0.01  $\mu F$  (C2)

should be connected between the unused input and the ground plane to provide a good high frequency bypass. The capacitor should be made larger for lower frequencies.

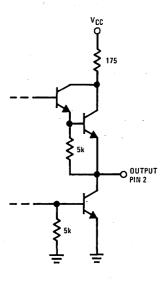
The input waveform may be sinusoidal, but below about 30 MHz the operation of the circuit becomes dependent on the slew rate of the input rather than amplitude. A square wave input with a slew rate of greater than 100 V/µs will permit correct operation down to lower frequencies, provided the proper input coupling capacitor is provided. If it is desired to use a TTL input signal source, the unused input should have a 10 k $\Omega$  resistor added to ground and the input coupling capacitor should be eliminated with the TTL source dc coupled to the input.

The device can be used in phase-locked loop applications such as FM radio or other communications bands to prescale the input frequency down to a more usable level. A digital frequency display system can also be derived separately or in conjunction with a phase-locked loop, and it can extend the useful range of many inexpensive frequency counters to 160 MHz (typically).

Input Configuration



Output Configuration



# National Semiconductor

## **Frequency Synthesis**

## **DS8627, DS8628 130/225 MHz Low Power Prescalers**

## **General Description**

The DS8627 and DS8628 are low power fixed ratio prescalers which divide by 24 and 20, respectively. The inputs can be driven either single or double-ended and they are buffered, providing 40/100 mVrms input sensitivity. The output provided is open-collector and is capable of interfacing with TTL and CMOS.

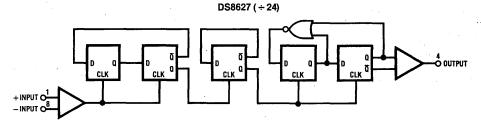
The device can be used in phase-locked loop applications such as FM radio or other communications bands to prescale the input frequency down to a more usable level. A digital frequency display system can also be derived

separately or in conjunction with a phase-locked loop, and it can extend the useful range of many inexpensive frequency counters to 225 MHz.

#### **Features**

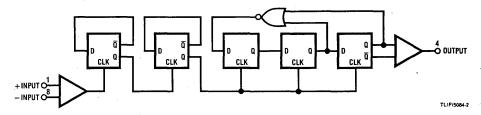
- Input frequency: 130 MHz (-4, -3); 225 MHz (-2, std)
- Low power: 10 mA (-4, -2); 7 mA (-3, std)
- Input sensitivity: 100 mVrms (-4, -3); 40 mVrms (-2, std)

## **Logic Diagrams**



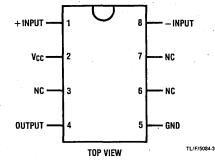
DS8628 ( ÷ 20)

TL/F/5084-1



## **Connection Diagram**

#### **Dual-In-Line Package**



Order Number DS8627N or DS8628N (-4, -3, -2) See NS Package N08E

## **Absolute Maximum Ratings (Note 1)**

V<sub>CC</sub> Supply Voltage 7V
V<sub>IN</sub> Input Voltage < V<sub>CC</sub>
Open-Collector Output Voltage 7V
Operating Free Air Temperature Range -30°C to +70°C
Storage Temperature Range -65°C to +150°C

## **Recommended Operating Conditions**

Symbol	Parameter	Conditions			DS8627-3 DS8628-3		DS8627-2 DS8628-2		DS8627 DS8628		Units
			Min	Max	Min	Max	Min	Max	Min	Max	
V <sub>CC</sub>	Supply Voltage		4.5	5.5	4.5	5.5	4.5	5.5	4.5	5.5	V
f <sub>MAX</sub>	Toggle Frequency	V <sub>IN</sub> = 100 mVrms	20	130	20	130	20	225	20	225	MHz
V <sub>IN</sub>	Input Signal Amplitude		100	300	100	300	40	300	40	300	mVrms
V <sub>SLW</sub>	Slew Rate		20		20		20		20		V/μs
loL	Low Level Output Current			3		3				3	mA

## DC Electrical Characteristics (Notes 2 and 3)

Symbol	Parameter	Conditions	DS8627-4 DS8628-4		DS8627-3 DS8628-3		DS8627-2 DS8628-2		DS8627 DS8628		Units
			Min	Max	Min	Max	Min	Max	Min	Max	
I <sub>CEX</sub>	Open-Collector High Level Output	Output = 5.5V		100		100		100		100	μА
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = 4.5V, I <sub>OL</sub> = 3 mA		0.4		0.4		0.4		0.4	٧
Icc	Supply Current	V <sub>CC</sub> = 5.5V		10		7		10		7	mA

## AC Electrical Characteristics V<sub>CC</sub> = 5V ± 10%, T<sub>A</sub> = -30°C to 70°C

Symbol Parameter		Conditions	Min	Max	Units	
R <sub>IN</sub>	AC Input Resistance	V <sub>IN</sub> = 100 MHz and 50 mVrms	1.0		kΩ	
CiN	Input Capacitance	VIN = 100 MH2 and 50 myrms	3	10	pF	

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -30°C to +70°C temperature range.

Note 3: All currents into device pins are shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

## **Application Hints**

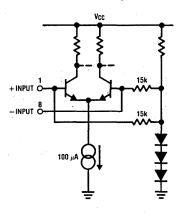
#### **OPERATING NOTES**

The signal source is usually capacitively coupled to the input. At higher frequencies a 0.001  $\mu F$  input capacitor is usually sufficient, with larger values used at the lower frequencies. If the input signal is likely to be interrupted, it may be desirable to connect a 100 kΩ resistor between one input and ground to stabilize the device. In the single-ended mode, it is preferable to connect the resistor to the unused input. In the differential mode, the resistor can be connected to either input. The addition of the 100 kΩ pull-down resistor causes a loss of input sensitivity, but prevents circuit oscillations under no signal (open circuit)

conditions. In addition, in the single ended mode, a capacitor of 0.001  $\mu$ F should be connected between the unused input and the ground plane to provide a good high frequency bypass. The capacitor should be made larger for lower frequencies.

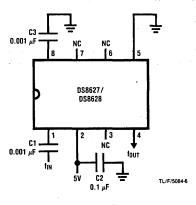
The input waveform may be sinusoidal, but below about 20 MHz the operation of the circuit becomes dependent on the slew rate of the input rather than amplitude. A square wave input with a slew rate of greater than 20V/µs will permit correct operation down to lower frequencies, provided the proper input coupling capacitor is provided.

## **Schematic Diagrams**





## **Typical Application**



## Frequency Synthesis PRELIMINARY

## DS8621 275 MHz/1.2 GHz VHF/UHF Prescaler

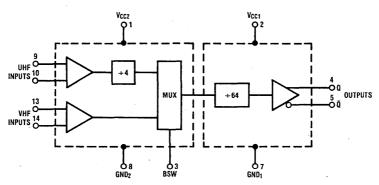
## **General Description**

The DS8621 is a low power, high speed prescaler intended for use in frequency synthesized television tuners. The device performs division by 64 from the VHF input and division by 256 from the UHF input. The VHF and UHF inputs are buffered providing 50 mVrms sensitivity at frequencies in excess of 275 MHz and 1.2 GHz respectively. (The VHF and UHF input signals can be applied either single or double-ended.) The TTL compatible bandswitch (BSW) input selects the VHF inputs when at a low level and the UHF inputs when at a high level. The outputs are complementary ECL structures which have controlled edge-transition rates to minimize spurious harmonic emissions. The device operates from a 5V  $\pm$  10% supply source.  $V_{\rm CC2}$  and GND $_{\rm 1}$  power the VHF and UHF input stages while  $V_{\rm CC1}$  and GND $_{\rm 1}$  power the remainder of the circuit, thus limiting internal feedback.

#### **Features**

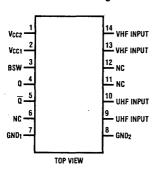
- Broadband operation
- High sensitivity
- Separate VHF and UHF inputs
- Low power
- Pin compatible with RCA (CA3179) and Motorola (MC12071)

## **Logic Diagram**



## **Connection Diagram**

#### Dual-In-Line Package



## **Logic Truth Table**

BSW	Input Mode	Modulus
0	VHF	64
1	UHF	256

Order Number DS8621N See NS Package N14A

### Absolute Maximum Ratings (Note 1)

V<sub>CC1</sub>, Supply Voltage 7V
V<sub>CC2</sub>, Supply Voltage 7V
Input Voltage 7V
Operating Free Air Temperature Range -30°C to +70°C
Storage Temperature Range -65°C to +150°C

## **Recommended Operating Conditions**

Symbol	Parameter	Conditions	Min	Max	Units	
	Supply Voltages	······································				
	V <sub>CC1</sub>		4.5	5.5	V	
	V <sub>CC2</sub>	n e	4.5	5.5	V	
f <sub>MAX</sub>	Toggle Frequency					
	VHF	$V_{IN} = 100 \text{ mVrms}$	80	275	MHz	
	UHF		, 80	1200	MHz	
V <sub>IN</sub>	Input Signal					
	Sensitivity			1		
	VHF	80 MHz-275 MHz	20	500	mVrms	
	UHF	80 MHz-450 MHz	100	500	mVrms	
	.	450 MHz-1200 MHz	50	500	mVrms	
	Input Slew Rate					
	VHF		20		V/μs	
	UHF		20	1	V/μs	
I <sub>он</sub>	High Level			- 300	μΑ	
	Output Current					
I <sub>OL</sub>	Low Level			300	μΑ	
	Output Current					

## DC Electrical Characteristics (Notes 2 and 3)

Symbol	Parameter	Conditions	Min	Max	Units
V <sub>IH</sub>	High Level BSW Input Voltage	V <sub>CC</sub> = 5.5V	- 2.0		V
V <sub>IL</sub>	Low Level BSW Input Voltage	V <sub>CC</sub> = 4.5V		0.8	V
l <sub>1</sub>	Max High Level BSW Input Current	V <sub>CC</sub> = 4.5V V <sub>IH</sub> = 7V		100	μА
l <sub>IH</sub>	High Level BSW Input Current	V <sub>CC</sub> = 4.5V V <sub>IH</sub> = 2.7V		20	μА
l <sub>IL</sub>	Low Level BSW Input Current	V <sub>CC</sub> = 5.5V V <sub>IL</sub> = 0.4V		- 100	μА
	Output Voltage Range	Refer to Output Load Diagram	0.75	1.6	Vp-p
Icc	Supply Current	V <sub>CC</sub> = 5.5V		32.0	mA

## AC Electrical Characteristics $V_{CC} = 5V \pm 10\%$ , $T_A = -30$ °C to +70°C

Parameter	Conditions	Min	Max	Units
Output Rise/Fall Time	Refer to Output Load Diagram	40	110	ns

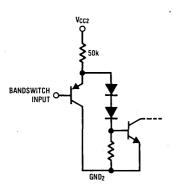
Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -30°C to +70°C temperature range.

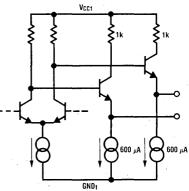
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

## **Typical Input/Output Schematics**

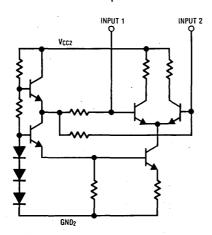
#### **Bandswitch Buffer**



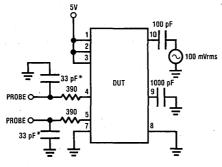
## Output Buffer



#### **UHF/VHF Input Buffers**



## **Output Load Diagram**



\* includes capacitance of probes

## Frequency Synthesis

## DS8622 500 MHz/1.2 GHz Dual Modulus VHF/UHF Prescaler

## **General Description**

The DS8622 is a low power broadband dual modulus prescaler intended for use in frequency synthesized television tuners. The device features separate VHF and UHF buffered inputs, VHF input division by 126 or 128, UHF input division by 252 or 256, TTL compatible bandswitch and modulus control inputs, complementary ECL outputs, and 5V operation.

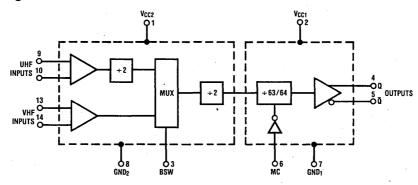
The VHF and UHF inputs cover a frequency range from 80 MHz to 1200 MHz and can be driven either single or double-ended. The bandswitch (BSW) input selects the VHF inputs when at a low level and the UHF inputs when at a high level. The modulus control (MC) input selects division by 126 or 252 when at a high level and division by 128 or 256 when at a low level. The dual modulus feature of this prescaler can provide frequency resolution steps of 3.9 kHz, 7.8 kHz, or 15.6 kHz as shown in the table of Pos-

sible Operating Conditions. The outputs are internally edge-transition controlled to minimize spurious harmonic emissions. The device operates from a standard 5V  $\pm$  10% supply source.  $V_{CC2}$  and  $GND_2$  power the VHF and UHF input stages, and  $V_{CC1}$  and  $GND_1$  power the remainder of the circuit, thus limiting internal feedback.

#### **Features**

- Broadband operation
- Increased frequency resolution
- High input sensitivity
- Separate VHF and UHF inputs
- Low power

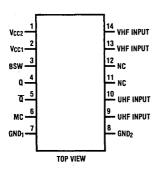
### **Logic Diagram**



## **Connection Diagram**

## **Logic Truth Table**

#### **Dual-In-Line Package**



BS	W	мс	Input Mode	Modulus
	0	0	VHF	128
(	0	1	VHF	126
	1 .	0	UHF	256
	1.	1	UHF	252

Order Number DS8622N See NS Package N14A

# Absolute Maximum Ratings (Note 1)

V<sub>CC1</sub>, Supply Voltage 7V Operating Free Air Temperature Range -30°C to +70°C V<sub>CC2</sub>, Supply Voltage 7V Storage Temperature Range -65°C to +150°C BSW, MC Input Voltage

# **Recommended Operating Conditions**

Symbol	Parameter	Conditions	Min	Max	Units
	Supply Voltages				
	V <sub>CC1</sub>		4.5	5.5	l v
	V <sub>CC2</sub>	1	4.5	5.5	) v
f <sub>MAX</sub>	Toggle Frequency				
	VHF	V <sub>IN</sub> = 100 mVrms	80	550	MHz
	UHF		80	1200	MHz
V <sub>IN</sub>	Input Signal				
	Sensitivity		1		Ì
	VHF	80 MHz-550 MHz	50	500	mVrms
	UHF	80 MHz-550 MHz	100	500	mVrms
		550 MHz-1200 MHz	50	500	mVrms
	Input Slew Rate				
	VHF		20		V/μS
	UHF		20		V/μs
Гон	High Level			- 300	μΑ
	Output Current				<u></u>
I <sub>OL</sub>	Low Level			300	μΑ
	Output Current				Į .

# DC Electrical Characteristics (Notes 2 and 3)

Symbol	Parameter	Conditions	Min	Max	Units
V <sub>IH</sub>	High Level Input Voltage (Note 4)	V <sub>CC</sub> =5.5V	2.0		V
V <sub>IL</sub>	Low Level Input Voltage (Note 4)	V <sub>CC</sub> = 4.5V		0.8	V
l <sub>i</sub>	Max Input Current (Note 4)	V <sub>CC</sub> = 4.5V V <sub>IH</sub> = 7V		100	μΑ
I <sub>IH</sub>	High Level Input Current (Note 4)	V <sub>CC</sub> = 4.5V V <sub>IH</sub> = 2.7V		20	- μΑ
I <sub>IL</sub>	Low Level Input Current (Note 4)	V <sub>CC</sub> = 5.5V V <sub>IL</sub> = 0.4V		- 100	μА
	Output Voltage Range	Refer to Output Load Diagram	0.75	1.6	Vp-p
Icc	Supply Current			32.0	mA

# AC Electrical Characteristics V<sub>CC</sub> = 5V ± 10%, T<sub>A</sub> = -30°C to +70°C

Symbol	Parameter	Conditions	Min	Max	Units
t MODULUS	Modulus Set-Up Time (Note 5)			65	ns
t <sub>SEL</sub>	BSW Select Time			20	μS
	Output Rise/Fall Time	Refer to Output Load Diagram	40	110	ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -30°C to +70°C temperature range.

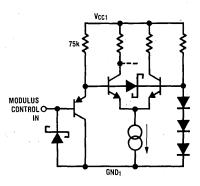
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Applies to BSW and MC inputs.

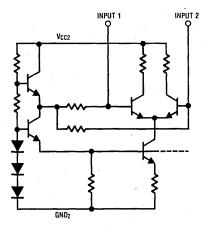
Note 5: t MODULUS = the period of time the modulus control level must be defined prior to the positive transition of the prescale output to ensure proper modulus selection.

# **Typical Input/Output Schematics**

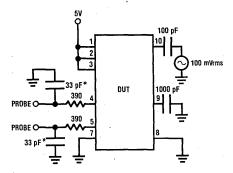
**Modulus Control Buffer** 



**UHF/VHF Input Buffers** 

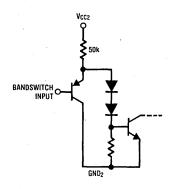


# **Output Load Diagram**

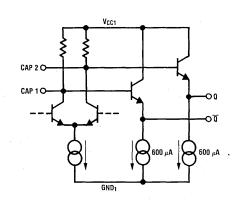


<sup>\*</sup> Includes capacitance of probes.

#### **Bandswitch Buffer**



**Output Buffer** 



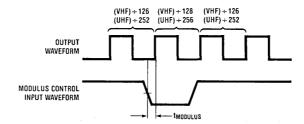
# POSSIBLE OPERATING CONDITIONS

Reference Frequency (kHz)	Mode	Frequency Resolution (kHz)	Min Lock Frequency* (MHz)
15.625	VHF	31.25	124.03125
	UHF	62.5	248.0625
7.8125	VHF	15.625	62.015625
7.0125	UHF	31.25	124.03125
3.90625	VHF	7.8125	31.0078
3.90625	UHF	15.625	62.015625

<sup>\*</sup>Frequencies obtainable using minimum continuous N code.

# **DS8622**

# **Timing Diagram**



The modulus control input level is sensed immediately prior to the output low-to-high level transition. The prescaler's modulus value will respond to the change in the modulus control input level immediately after that same output low-to-high level transition.

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# **Digital PLL Synthesis**

National Semiconductor Application Note 335 Craig Davis Tom Mills Keith Mueller April 1983



## I. System Concepts

#### INTRODUCTION

Digital tuning systems are fast replacing the conventional mechanical systems in AM/FM and television receivers. The desirability of the digital approach is mainly due to the following features:

- · Precise tuning of station frequencies
- · Exact digital frequency display
- · Keyboard entry of desired frequency
- · Virtually unlimited station memory
- · Up/down scanning through the band
- Station "search" (stop on next active station)
- · Power on to the last station
- Easy option for time-of-day clock

In addition, recent developments in large scale integrated circuit technology and new varactor diodes for the AM band have made the cost-benefit picture for digital tuning very attractive. System partitioning is extremely important in optimizing this cost-benefit picture, as will be discussed.

#### SYSTEM DESCRIPTION

A simplified block diagram of a typical digitally tuned receiver is shown in *Figure 1*. Notice this receiver could be one for AM, FM, marine radio, or television; it makes no difference. The frequency synthesizer block generates the local oscillator frequency for the receiver, just as a conventional mechanical tuner would. However, the phase-locked-loop (PLL) acts as an integral frequency multiplier of an accurate crystal controlled reference frequency while the mechanical type provides a continuously variable frequency output with no reference. Some method of controlling the value of the multiplier for channel tuning must be provided. The other RF, IF, and audio/video circuitry will be the same as in the mechanical tuning method.

There are many different ways to partition the frequency synthesizer system to perform the digital tuning function.

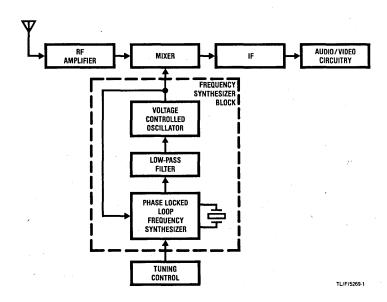


FIGURE 1. Block Diagram of a Digitally Tuned Receiver

COPS<sup>TM</sup> is a trademark of National Semiconductor Corp.

#### PROGRAMMABLE CONTROLLER FUNCTION

The most cost-effective application of different IC process technologies is shown in Figure 2. The controller is separate from the PLL. The controller can be as simple as a mask programmable microcontroller\* or as complicated as a high-powered microprocessor system. It can be done most economically with NMOS technology because of the logic density possible and the small size of the RAM/ROM memory cells. It could also be CMOS for extremely low power consumption in standby mode.

#### **BASIC PHASE-LOCKED-LOOP FUNCTION**

The DS8906/7/8 series of PLLs utilize a dual-modulus frequency synthesis technique. The reasons for this and the PLL itself will now be discussed.

Figure 3 is a diagram of the most simple phase-lockedloop. A particular reference frequency is generated by a crystal oscillator and some fixed divider, and this goes \*Such as National's COPSTM family.

VCO as a DC control voltage. In lock, the phase error must be zero, so fin equals free. This system provides only one output frequency, that

into one side of a digital phase comparator. A voltage con-

trolled oscillator (VCO) feeds directly into the other input

of the phase comparator. The output of the phase compar-

ator is an error signal which is filtered and fed back to the

being equal to the reference frequency.

Figure 4 is basically the same but now a programmable divide-by-N counter is between the VCO and the phase comparator. The input to the phase comparator (f<sub>IN</sub>) now becomes the output frequency of the VCO (f<sub>OUT</sub>) divided by N, where N is the division code loaded into the programmable counter. This means four/N must equal fREF. Thus, the VCO output frequency becomes  $N \times f_{REF}$ , and  $f_{OUT}$  can now be changed in integral steps of fREF by merely changing N.

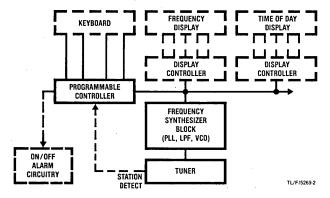


FIGURE 2. System Block Diagram

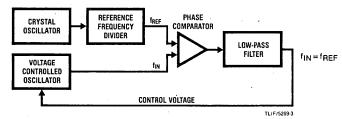


FIGURE 3. Basic Phase-Locked-Loop

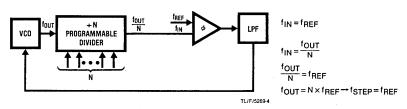


FIGURE 4. Basic PLL Frequency Synthesizer

In applications where the output frequency desired exceeds the maximum clock frequency of available programmable dividers, a common solution is to add a prescaler preceding the programmable divider, as shown in Figure 5. In this case  $f_{\rm OUT}=N$  (M  $\times$   $f_{\rm REF})$  and so the output frequency step size becomes M  $\times$   $f_{\rm REF}$ . So, while this technique allows higher frequency operation, it does so at the expense of either increased channel spacing for a given reference frequency, or decreased reference frequency if a specific channel spacing is required. This latter limitation is often undesirable as it can cause increased lock-on time, decreased scanning rates, and sidebands at undesirable frequencies.

Figure 6 shows the basic dual-modulus scheme. Here, a dual-modulus prescaler is substituted for the fixed prescaler and the modulus is controlled by programmable counters. The advantage to this approach is that the step size is again equal to the reference frequency while the prescaling still allows the programmable counters to operate at lower frequencies. As in the fixed prescale technique, only the prescaler needs to be high speed. The DS8906/7/8 prescale by 7/8 for AM and in a similar fashion by 63/64 in FM.

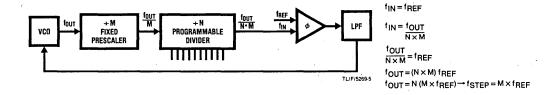


FIGURE 5. PLL Frequency Synthesizer with Fixed Prescaler

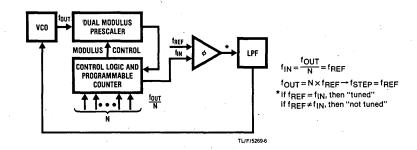


FIGURE 6. Basic Dual-Modulus Frequency Synthesizer

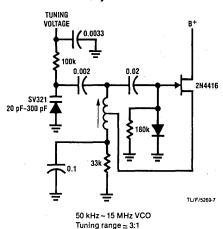
# **II. Application Hints**

#### **VOLTAGE CONTROLLED OSCILLATORS**

In all radio and television applications, the voltage controlled oscillator (VCO) is a varactor tuned, LC type of circuit. The LC circuit is used over the various RC current controlled circuits because of their superior noise characteristics. *Figure* 7 shows a collection of popular VCOs used in radio and television tuners. The AM VCO is a Hartley design chosen for wide tuning range. Commonly used varactors will show a capacitance change of 350 pF at 1V to 20 pF at 8V, which if used in a low capacitance oscillator circuit, can produce a tuning range approaching 3 to 1.

In the higher frequency ranges, above 50 MHz, Colpitts oscillators are used because stray circuit capacitance will be in parallel with desired feedback capacitance and not cause undesirable spurious resonances that might occur with the tapped coil Hartley design. The FM VCO shown is a grounded base design with feedback from collector to emitter. A UHF television oscillator is also shown. It too is a grounded base oscillator, but using a transmission line as the resonant element instead of a coil. The transmission line and tuning capacitors are arranged in  $\pi$  network which offers improved noise characteristics over a parallel tuned circuit. This circuit will tune over almost an octave.

#### Hartley Oscillator



#### **Colpitts Oscillator**

# TUNING VOLTAGE 470 pF 470 pF 1000 pF 5.6k PROCESS 43 15 pF 1 L 1000 pF 5.6k

50 MHz ~ 300 MHz VCO Tuning range ~ 2:1

#### Colpitts Oscillator

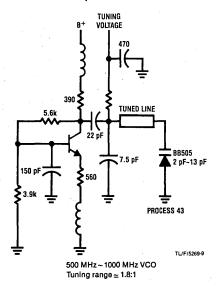


FIGURE 7. Typical VCO Circuits (Typical Values Shown)

11-43

11

#### PLL LOOP FILTER CALCULATIONS

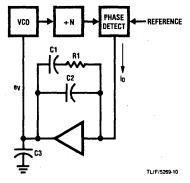
Andrzej Przedpelski, in two articles published in Electronic Design (#19, Sept. 13, 1978 and #10, May 10, 1978) explains how to calculate the three time constants associated with a third order type 2 loop which is typically used with the DS8906/7/8 series. Figure 8 explains his method and shows a sample calculation. His articles illustrate how to calculate three time constants, and plot open loop gain and phase, and closed loop noise response.

It should be noted that VCO gain,  $K_V$ , is in terms of radians per second per volt, and phase detector gain,  $K_D$ , is in terms of amps per radian. The phase detector gain for the DS8906/7/8 series is  $\pm 1_{OUT}$  divided by  $4\pi$ .

Figure 9 illustrates an example calculation of time constants, and a plot of open loop gain and phase based on the preceding analysis.

#### REFERENCES

- 1. 'Manassewitsch V., "Frequency Synthesizers" (Wiley, New York, 1976)
- Rohde, A. L., "Digital PLL Frequency Synthesizers" (Prentice Hall, Englewood Cliffs, 1983)
- Egan, W.F., "Frequency Synthesis By Phase Lock" (Wiley, New York, 1981)



T1 = R1C1

T2 = R1C2

$$\frac{e_V}{I_O} = \frac{1 + ST1}{SC1 (1 + ST2)}$$

$$G(S) = \frac{K_D K_V}{NS^2C1} \left( \frac{1 + ST1}{1 + ST2} \right)$$

$$T2 = \frac{1 - \tan \phi \cos \phi}{\omega_O \cos \phi}$$

$$T1 = \frac{1}{\omega_O^2T2}$$

$$C1 = \frac{K_D K_V}{N\omega_O 2} \left( \frac{-\omega_O T1 - 1}{\omega_O T2 + 1} \right)$$
where  $\theta$  = desired phase margin
$$\omega_O = \text{loop natural frequency}$$

$$\sim \text{closed loop bandwidth}$$
Note: DS8908 op amp requires C3  $\sim$  1000 pF for compensation.

#### FIGURE 8. Third Order Type 2 Loop

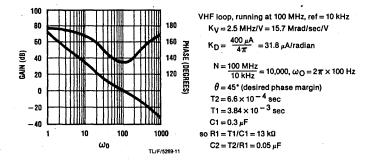


FIGURE 9. Example of Gain and Phase Calculation

## **DUAL-MODULUS COUNTING RANGE LIMITATIONS**

- . Minimum count limitations
- . Maximum count limitations

The DS8906/7/8 series PLLs utilize a dual-modulus counting scheme internally based on a 63/64 prescale modulus in FM mode in order that all of the U.S. FM frequency assignments could be reached using a 25 kHz reference. The counter modulus N = 64A + B where B is the 6 least significant bits of N and A is the 7th and greater significant bits of N.

$$N = 64A + B$$
  
 $N = 64A + \overline{63} - B (B = 63 - \overline{B})$   
 $1 + N = 64A + 63 + 1 - 64\overline{B} + 63\overline{B}$   
 $1 + N = 64 (A + 1 - \overline{B}) + 63\overline{B}$ 

The last equation is in the final form used internally by the DS8906/7/8. The equation indicates that, if N is loaded into the device, it will solve for N+1.

The minimum continuous N modulus (code) the equation dictates should occur when  $A=\overline{B}.\ \overline{B}$  maximum = 63 implies  $A=\overline{62},\ B=63$  should be an illegal N+1 code (N+1=3969). However, because this is just inside the lower FM band limits, extra circuitry was added to enable this particular code's operation. The actual minimum N+1 code for these PLLs thus becomes the case when  $A=61, \overline{B}=61, N+1$  minimum = 3907. There are legitimate N+1 codes below this 3907 value, however, they are not continuous. (i.e., Starting at 3907 and counting down, one additional code is in error every 63 codes. Thereafter, these erroneous codes are the cases where  $A<\overline{B}$ .) The sequence of illegal codes is shown in Figure 10.

Loaded Value of N	A	B	Status	Actual Locked N + 1 Value
3906	61	61	ок	3907
3905	61	62	illegal	3907
3904	61	63	illegal	3907
3903	60	0	OK	3904
•	•	•		•
•	•	•	•	
•	•	•	•	•
3843	60	60	ок	3844
3842	60	61	illegal	3844
3841	60	62	illegal	3844
3840	60	63	illegal	3844
3839	59	0	ок	3840
•	•	•	•	•
•	•	•	• '	. •
. •	•	•	•	•
3780	59	59	OK	3781
3779	59	60	illegal	3781
3778	59	61	illegal	3781
3777	59	62	illegal	3781
3776	59	63	illegal	3781
3775	58	0	ок	3776
•	•	. •	•	•
•	•	•	•	•
•	•	•	•	•
3717	- 58	58	OK	3718
3716	58	59	illegal	3718
3715	58	59	illegal	3718
3714	58	60	illegal	3718
3713	58	61	illegal	3718
3712	58	63	illegal	3718
3711	57	0	OK	3712
•	•	•	•	•
•	•	•	•	•
· ·	•	•	•	TL/F/5269-12

FIGURE 10. FM Mode Dual-Modulus Counting Below the Minimum Continuous N Code of 3906

11-45

Maximum code limits for these dual-modulus PLLs are determined by the N code bit length. The DS8906 and DS8908 have a 14-bit N counter allowing 16,383 counts. The DS8907 has a 13-bit N node length, allowing a maximum N count of 8,191. See Figure 11 for table operating ranges of the DS8906, DS8907 and DS8908 PLLs.

#### CONCLUSION

The major application for the DS8906/7/8 PLLs are synthesizers for AM-FM radios, and have been widely accepted in the marketplace. *Figure 12* shows the block diagram of such a radio. In this application the following performance relating to the PLL tuning system is realized.

PLL Loop Bandwidth	300 Hz
Reference Frequency Sidebands	>60 dB
Signal-to-Noise Ratio	
AM: 30% modulation	>50 dB
FM: 22.5 kHz deviation	>55 dB
Switching Speed (one channel)	<1.5 ms

<b>D</b> 1	T	Ref	f <sub>IN</sub> (I	Hz)
Product	Input	(Hz)	Min*	Max
DS8906 ·	AM	500	24.5k	8.193M
	FM	12.5k	48.8375M	120M
DS8907	AM	10k	490k	15M
	FM	25k	97.675M	120M
DS8908	AM	1k	49k	15M
		9k	441k	15M
		10k	490k	15M
		20k	980k	15M
	FM	1k	3.907M	15M
		9k	35.163M	120M
		10k	39.07M	120M
		20k	78.14M	120M

TL/F/5269-13

FIGURE 11. Product Operating Frequency Range

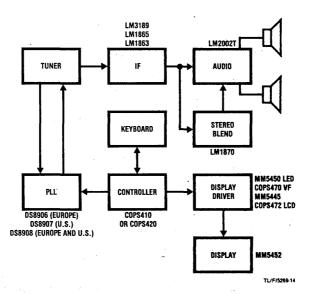


FIGURE 12. AM-FM Digitally Tuned Radio System

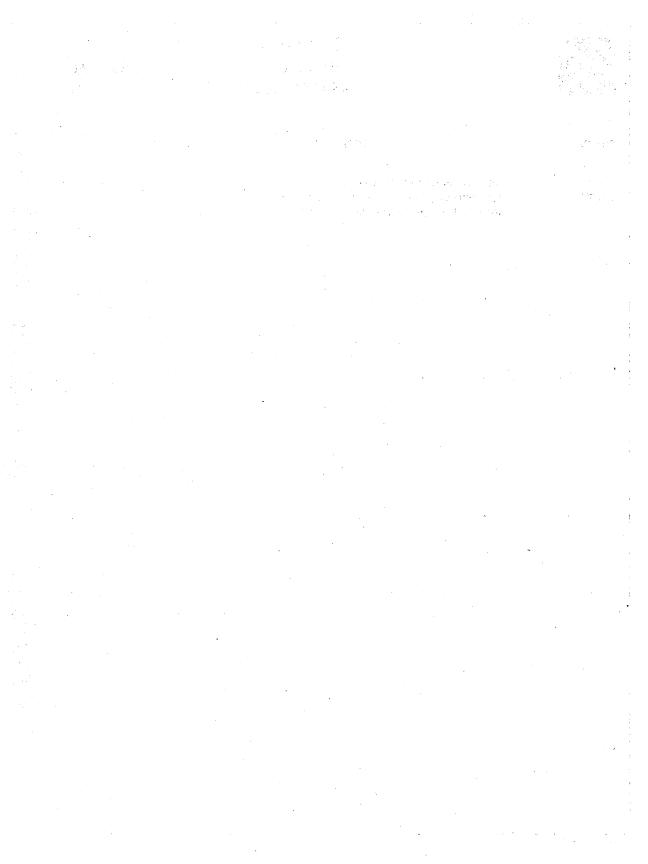
<sup>\*</sup>The minimum frequency shown is obtained when the minimum continuous N code is utilized and it assumes the edge rates > 20V/µs.



# Section 12 Interface Appendices



DEVICE	DESCRIPTION	PAGE NUMBER
	Interface Cross Reference Guide	12-3
AN-336	Understanding Integrated Circuit Package Power Capabilities	12-11
	Industry Package Cross Reference Guide	12-16



# **Interface Cross Reference Guide**

Device Designation	National's Direct Replacement	National's Closest Replacement
AMD		
AM26LS30DC AM26LS30PC AM26LS31DC AM26LS31PC AM26LS32DC AM26LS32PC AM26LS33DC AM26LS33DC	DS3691J DS3691N DS26LS31CJ DS26LS31CN DS26LS32ACJ DS26LS32ACN DS26LS33ACJ DS26LS33ACJ	DS26LS32CJ DS26LS32CN DS26LS33CJ DS26LS33CN
AM26S10DC AM26S10PC AM26S11DC AM26S11PC AM26S12DC AM26S12PC	DS26S10J DS26S10N DS26S11J DS26S11N	DS8838J DS8838N
, AM2965DC , AM2965PC , AM2966DC , AM2966PC		DP84240J DP84240N DP84244J DP84244N
N8T26AB N8T26AF N8T28F N8T28N	DS8T26AN DS8T26AJ DS8T28J DS8T28N	
D8212 P8212 D8216 P8216	DP8212J DP8212N DP8216J DP8216N	
D8224 AM8224PC D8226 P8226	DP8224J DP8224N DP8226J DP8226N	
AM8228PC D8228 AM8238PC D8238 DP8303J DP8303N DP8304BJ DP8304BN DP8307J DP8307N	DP8228N DP8228J DP8238N DP8238J DP8303J DP8303N DP8304BJ DP8304BN DP8307J DP8307N	
DP8308J DP8308N DS8838J DS8838N	DP8308J DP8308N DS8838J DS8838N	

The manufacturer's most current data sheets take precedence over this guide.

# National Semiconductor

# Interface Cross Reference Guide (Continued) 2 National Semiconductor

	Device Designation	National's Direct Replacement	National's Closest Replacement	Device Designation	National's Direct Replacement	National's Closest Replacement
	FAIRCHILD			,		
	μΑ1488DC μΑ1488PC μΑ1489ADC μΑ1489APC μΑ1489DC μΑ1489PC	DS1488J DS1488N DS1489AJ DS1489AN DS1489J DS1489N		9636ARC 9636ATC 9637ARC 9637ATC 9640DC 9640PC	DS26S10J DS26S10N	DS3691J DS3691N DS3486J DS3486N
	μA3680DC μA3680PC	DS3680J DS3680N	•	9643PC 9643TC	D0200 (0)(	DS75322N DS75322N
	75107ADC 75107APC 75107BDC 75107BPC	DS75107J DS75107N	DS75107J DS75107N	9645DC 9645PC		DS3245J DS3245N
	75108ADC 75108APC 75108BDC 75108BPC	DS75108J DS75108N	DS75108J DS75108N			
	75150RC 75150TC 75154DC 75154PC	DS75150J-8 DS75150N DS75154J DS75154N				
	75450BDC 75450BPC	DS75450J DS75450N				
	75451ARC 75451ATC 75451BRC 75451BTC	DS75451J-8 DS75451N DS75451J-8 DS75451N		· ·		
	75452ARC 75452ATC 75452BRC 75452BTC	DS75452J-8 DS75452N DS75452J-8 DS75452N				
	75453ARC 75453ATC 75453BRC 75453BTC	DS75453J-8 DS75453N DS75453J-8 DS75453N				
	75461RC 75461TC 75462RC 75462TC	DS75461J-8 DS75461N DS75462J-8 DS75462N			,	
	75471TC 75472TC		DS3611N DS3612N		•	
	75491PC 75492PC 75492APC	DS75491N DS75492N	DS75492N			1
	μΑ8T26ADC μΑ8T26APC μΑ8T28DC μΑ8T28PC	DS8T26AJ DS8T26AN DS8T28J DS8T28N		•	•	
The	9614DC 9614PC 9615DC 9615PC 9616DC 9616PC 9617DC 9617DC 9617PC	DS75114J DS75114N DS75115J DS75115N	DS1488J DS1488N DS1489AJ DS1489J DS75154N			

# Interface Cross Reference Guide (Continued)

Device Designation	National's Direct Replacement	National's Closest Replacement
INTEL		
D3245	DS3245J	
D8212 P8212 D8216 P8216	DP8212J DP8212N DP8216J DP8216N	
D8224 D8224 D8226 P8226	DP8224J DP8224N DP8226J DP8226N	
D8228 D8228 D8238 P8238	DP8228J DP8228N DP8238J DP8238N	
D8286 P8286 D8287 P8287	DP8304BJ DP8304BN DP8303J DP8303N	

The manufacturer's most current data sheets take precedence over this guide.

# 2 National Semiconductor

Device Designation	National's Direct Replacement	National's Closest Replacement
MMI	-	
74S408N	DP8408N	
74S409N	DP8409N	
74S780N	DP8400N	

The manufacturer's most current data sheets take precedence over this guide.

# Interface Cross Reference Guide (Continued)

# National Semiconductor

Device Designation	National's Direct Replacement	National's Closest Replacement	Device Designation	National's Direct Replacement	National's Closest Replacement
MOTOROLA	neplacement	nepiacement		neplacement	neplacement
MMH0026CG MMH0026CL MMH0026CN MMH0026CP1 MMH0026G MMH0026L	DS0026CH DS0026CJ DS0026CN DS0026CN DS0026H DS0026J	DS0026CG	MC75125P MC75127L MC75127P MC75128L MC75128P MC75129L MC75129P	DS75125N DS75127J DS75127N DS75128J DS75128N DS75129J DS75129N	
MC12015P MC12016P MC12017P MC12071P	DS8615N DS8616N DS8617N DS8621N		MC75325L MC75491P	DS75325J DS75491N	
MC1472P1 MC1472P1 MC1472U MC1472U MC1488L MC1488P MC1489AL MC1489AP	DS1488J DS1488N DS1489AJ DS1489AN	DS3612N DS3632N DS3612J-8 DS3632J-8	MC75492P  MC8T13L  MC8T13P  MC8T14L  MC8T14P  MC8T23L  MC8T23P  MC8T24L  MC8T24P	DS75492N DS75121J DS75121N DS75122J DS75122N DS75123J DS75123N DS75124J DS75124J	
MC1489L MC1489P	DS1489J DS1489N		MC8T26AL MC8T26AP	DS8T26AJ DS8T26AN	DS8834J DS8834N
AM26LS31DC AM26LS31PC	DS26LS31CJ DS26LS31CN		MC8T28L MC8T28P	DS8T28J DS8T28N	
MC26S10L MC26S10P	DS26S10J DS26S10N	,	DS8641N DS8641J	DS8641N DS8641N	r
MC3430L MC3430P MC3431L MC3431P MC3432L MC3432P MC3433L MC3433P MC3437L MC3437P MC3438L MC3438P	DS3651J DS3651N DS3653J DS3653N DS8837J DS8837N DS8838J DS8838N	DS3651J DS3651N DS3653J DS3653N			
MC3450L MC3450P MC3451P MC3452P	DS3652N	DS3650J DS3650N DS3451N			
MC3486L MC3486P MC3487L MC3487P	DS3486J DS3486N DS3487J DS3487N				
MC3490P MC3491P MC3494P		DS8887N DS8889N DS8897N			
MC6880AL MC6880AP	DS8T26AJ DS8T26AN				
MC6889L MC6889P	DS8T28J DS8T28N				
MC75107L MC75107P MC75108L MC75108P MC75125I	DS75107J DS75107N DS75108J DS75108N DS75125J				

The manufacturer's most current data sheets take precedence over this guide.

Device Designation	National's Direct Replacement	National's Closest Replacement
SIGNETICS		
MC1488F MC1488N MC1489AN MC1489AF MC1489F MC1489N	DS1488J DS1488N DS1489AN DS1489AJ DS1489J DS1489N	
NE582F		DS75494J
NE582N 75S107F 75S107N 75S108F 75S108N 75S207F 75S207N 75S208F 75S208N		DS75494N DS75107J DS75107N DS75108J DS75108N DS75207J DS75207N DS75208J DS75208N
N8T13F N8T13N N8T14F N8T14N N8T15F N8T15N	DS75121J DS75121N DS75122J DS75122N	DS75150J-8 DS75150N
N8T23F N8T23N N8T24F N8T24N N8T26AF N8T26AN N8T28F N8T28N	DS75123J DS75123N DS75124J DS75124N DS8T26AJ DS8T26AN DS8T28J DS8T28N	
N8T34F N8T34N N8T37F N8T37N N8T38F N8T38N N8T380F N8T380N	DS8834J DS8834N DS8837J DS8837N DS8838J DS8838N DS8836J DS8836N	DS8640J DS8640N
DS8820AF DS8820AN DS8820F DS8820N	DS8820AJ DS8820AN DS8820J DS8820N	
DS8830F DS8830N DS8880F DS8880N	DS8830J DS8830N DS8880J DS8880N	

The manufacturer's most current data sheets take precedence over this guide.

<sup>\*</sup>Signetics has announced plans to obsolete these products.

#### National's National's Device Closest Direct Designation Replacement Replacement **SPRAGUE** UDN3611H DS3611J-8 UDN3611M DS3611N UDN3612H DS3612J-8 UDN3612M DS3612N UDN3613H DS3613J-8 UDN3613M DS3613N UDN3614H DS3614J-8 UDN3614M **DS3614N**

Interface Cross Reference Guide (Continued)

The manufacturer's most current data sheets take precedence over this guide.

# Interface Cross Reference Guide (Continued)

# National Semiconductor

•	Device Designation	National's Direct Replacement	National's Closest Replacement	Device Designation	National's Direct Replacement	National's Closest Replacement
_	TEXAS INSTRUMENT	rs	<del></del>			
	MC1488J MC1488N MC1489AJ MC1489AN MC1489J MC1489N	DS1488J DS1488N DS1489AJ DS1489AN DS1489J DS1489N		SN75189AN SN75189J SN75189N SN75207BN SN75207J	DS1489AN DS1489J DS1489N DS75207N	DS75207J
	AM26LS31CJ AM26LS31CN AM26LS32ACJ AM26LS32ACN AM26LS33AJ	DS26LS31CJ DS26LS31CN DS26LS32ACJ DS26LS32ACN DS26LS33ACJ	DS26LS32CJ DS26LS32CN DS26LS33CJ	SN75208BJ SN7520BJ SN75208N SN75325J SN75325N SN75361AJG	DS75208J  DS75325J  DS75325N  DS75361J-8	DS75208J DS75208N
	AM26LS33AN AM26S10CJ AM26S10CN AM26S11CJ AM26S11CN	DS26LS33ACN DS26S10J DS26S10N DS26S11J DS26S11N	DS26LS33CN	SN75361AP SN75365J SN75365N SN75369J SN75369N	DS75361N DS75365J DS75365N	DS0026CJ-8 DS0026CN
	MC3486J MC3486N MC3487J MC3487N SN74LS424J	DS3486J DS3486N DS3487J DS3487N DP8224J		SN75437ANE SN75437NE SN75450BJ SN75450BN SN75451BJG	DS3658N DS3658N DS75450J DS75450N DS75451J-8	
	SN74LS424N SN74S412J SN74S412N SN74S428N SN74S436N SN74S437N SN74S437N SN74S438N	DP8224N DP8212J DP8212N DP8228N DS36149N DS36179N DP8238N		SN75451BP SN75452BJG SN75452BP SN75453BJG SN75453BP SN75454BJG SN75454BP	DS75451N DS75452J-8 DS75452N DS75453J-8 DS75453N DS75454J-8 DS75454N	
	SN75107AJ SN75107AN SN75107BJ SN75107BN SN75108AJ SN75108AJ SN75108BJ SN75108BN	DS75107J DS75107N DS75108J DS75108N	DS75107J DS75107N DS75108J DS75108N	SN75461JG SN75461P SN75462JG SN75462P SN75463JG SN75463P SN75464JG SN75464JG	DS754611.8 DS75461N DS754621.8 DS75462N DS75463N DS75463N DS754641.8 DS75464N	
	SN75113J SN75113N SN75114J SN75114N SN75115J SN75115N	DS75113J DS75113N DS75114J DS75114N DS75115J DS75115N		SN75471JG SN75471P SN75472JG SN75472P SN75473JG SN75473P		DS3611J-8 DS3611N DS3612J-8 DS3612N DS3613J-8 DS3613N
	SN75121J SN75121N SN75122J SN75122N SN75123J SN75123N	DS75121J DS75121N DS75122J DS75122N DS75123J DS75123J		SN75474JG SN75474P SN75477JG SN75477P SN75480N SN75491AN	DS8880N	DS3614J-8 DS3614N DS3612J-8 DS3612N
	SN75124J SN75124N SN75125J SN75125N SN75127J	DS75124J DS75124N DS75125J DS75125N DS75127J		SN75491N SN75492AN SN75492J SN75492N SN75494N	DS75491N DS75492J DS75492N	DS75492N DS75494N
	SN75127N SN75128J SN75128N SN75129J .SN75129N	DS75127N DS75128J DS75128N DS75129J DS75129N		N8T13J N8T13N N8T14J N8T14N N8T23J	DS75121J DS75121N DS75122J DS75122N DS75123J	
	SN75150J SN75150N SN75154J SN75154N SN75160N	DS75150J-8 DS75150N DS75154J DS75154N DS75160AN		N8T23N N8T24J N8T24N N8T26AJ N8T26AN	DS75123N DS75124J DS75124N DS8T26AJ DS8T26AN	
	SN75160AN SN75161N SN75161AN SN75162N SN75162AN	DS75160AN DS75161AN DS75161AN DS75162AN DS75162AN		DS8820AJ DS8820AN DS8830J DS8830N	DS8820AJ DS8820AN DS8830J DS8830N	
	SN75182J SN75182N SN75183J SN75183N SN75188J	DS8820AJ DS8820AN DS8830J DS8830N DS1488J		DS8831J DS8831N DS8832J DS8832N	DS8831J DS8831N DS8832J DS8832N	
	SN75188N SN75189AJ	DS1488N DS1489AJ				

The manufacturer's most current data sheets take precedence over this guide.

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# Understanding Integrated Circuit Package Power Capabilities

National Semiconductor Application Note 336 Charles Carinalli Josip Huljev March 1983



#### INTRODUCTION

The short and long term reliability of National Semiconductor's interface circuits, like any integrated circuit, is very dependent on its environmental condition. Beyond the mechanical/environmental factors, nothing has a greater influence on this reliability than the electrical and thermal stress seen by the integrated circuit. Both of these stress issues are specifically addressed on every interface circuit data sheet, under the headings of Absolute Maximum Ratings and Recommended Operating Conditions.

However, through application calls, it has become clear that electrical stress conditions are generally more understood than the thermal stress conditions. Understanding the importance of electrical stress should never be reduced, but clearly, a higher focus and understanding must be placed on thermal stress. Thermal stress and its application to interface circuits from National Semiconductor is the subject of this application note.

#### **FACTORS AFFECTING DEVICE RELIABILITY**

Figure 1 shows the well known "bathtub" curve plotting failure rate versus time. Similar to all system hardware (mechanical or electrical) the reliability of interface integrated circuits conform to this curve. The key issues associated with this curve are infant mortality, failure rate, and useful life.

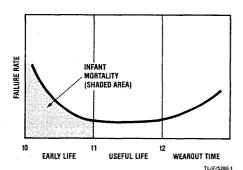


FIGURE 1. Failure Rate vs Time

Infant mortality, the high failure rate from time t0 to t1 (early life), is greatly influenced by system stress conditions other than temperature, and can vary widely from one application to another. The main stress factors that contribute to infant mortality are electrical transients and noise, mechanical maltreatment and excessive temperatures. Most of these failures are discovered in device test, burn-in, card assembly and handling, and initial system test and operation. Although important, much literature is available on the subject of infant mortality in integrated circuits and is beyond the scope of this application note.

Failure rate is the number of devices that will be expected to fail in a given period of time (such as, per million hours). The mean time between failure (MTBF) is the average time (in hours) that will be expected to elapse after a unit has failed before the next unit failure will occur. These two primary "units of measure" for device reliability are inversely related:

Although the "bathtub" curve plots the overall failure rate versus time, the useful failure rate can be defined as the percentage of devices that fail per-unit-time during the flat portion of the curve. This area, called the useful life, extends between t1 and t2 or from the end of infant mortality to the onset of wearout. The useful life may be as short as several years but usually extends for decades if adequate design margins are used in the development of a system.

Many factors influence useful life including: pressure, mechanical stress, thermal cycling, and electrical stress. However, die temperature during the device's useful life plays an equally important role in triggering the onset of wearout.

## **FAILURE RATES VS TIME AND TEMPERATURE**

The relationship between integrated circuit failure rates and time and temperature is a well established fact. The occurrence of these failures is a function which can be represented by the Arrhenius Model. Well validated and predominantly used for accelerated life testing of integrated circuits, the Arrhenius Model assumes the degradation of a performance parameter is linear with time and that MTBF is a function of temperature stress. The temperature dependence is an exponential function that defines the probability of occurrence. This results in a formula for expressing the lifetime or MTBF at a given temperature stress in relation to another MTBF at a different temperature. The ratio of these two MTBFs is called the acceleration factor F and is defined by the following equation:

$$F = \frac{X1}{X2} = \exp \left[ \frac{E}{K} \left( \frac{1}{T2} - \frac{1}{T1} \right) \right]$$

Where: X1 = Failure rate at junction temperature T1 X2 = Failure rate at junction temperature T2

> T = Junction temperature in degrees Kelvin E = Thermal activation energy in electron volts

(ev)

K = Boltzman's constant

However, the dramatic acceleration effect of junction temperature (chip temperature) on failure rate is illustrated in a plot of the above equation for three different activation energies in *Figure 2*. This graph clearly demonstrates the importance of the relationship of junction temperature to device failure rate. For example, using the 0.99 ev line, a 30 degree rise in junction temperature, say from 130°C to 160°C, results in a 10 to 1 increase in failure rate.

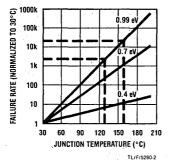


FIGURE 2. Failure Rate as a Function of Junction Temperature

#### **DEVICE THERMAL CAPABILITIES**

There are many factors which affect the thermal capability of an integrated circuit. To understand these we need to understand the predominant paths for heat to transfer out of the integrated circuit package. This is illustrated by Figures 3 and 4.

Figure 3 shows a cross-sectional view of an assembled integrated circuit mounted into a printed circuit board.

Figure 4 is a flow chart showing how the heat generated at the power source, the junctions of the integrated circuit, flows from the chip to the ultimate heat sink, the ambient environment. There are two predominant paths. The first is from the die to the die attach pad to the surrounding package material to the package lead frame to the printed circuit board and then to the ambient. The second path is from the package directly to the ambient air.

Improving the thermal characteristics of any stage in the flow chart of *Figure 4* will result in an improvement in device thermal characteristics. However, grouping all these characteristics into one equation determining the overall thermal capability of an integrated circuit/package/environmental condition is possible. The equation that expresses this relationship is:

$$T_{J} = T_A + P_D(\theta_{JA})$$

Where:  $T_J = Die junction temperature$ 

T<sub>A</sub> = Ambient temperature in the vicinity of the device

 $P_D$  = Total power dissipation (in watts)  $\theta_{JA}$  = Thermal resistance junction-to-ambient

 $\theta_{\mathrm{JA}}$ , the thermal resistance from device junction-to-ambient temperature, is measured and specified by the manufacturers of integrated circuits. National Semiconductor utilizes special vehicles and methods to measure and monitor this parameter. All interface circuit data sheets specify the thermal characteristics and capabilities of the packages available for a given device under specific conditions—these package power ratings directly relate to thermal resistance junction-to-ambient or  $\theta_{\mathrm{JA}}$ .

Although National provides these thermal ratings, it is critical that the end user understand how to use these numbers to improve thermal characteristics in the development of his system using interface components.

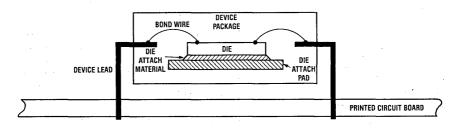


FIGURE 3. Integrated Circuit Soldered into a Printed Circuit Board (Cross-Sectional View)

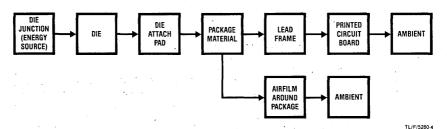


FIGURE 4. Thermal Flow (Predominant Paths)

# DETERMINING DEVICE OPERATING JUNCTION TEMPERATURE

From the above equation the method of determining actual worst-case device operating junction temperature becomes straightforward. Given a package thermal characteristic,  $\theta_{\rm JA}$ , worst-case ambient operating temperature,  $T_{\rm A}({\rm max})$ , the only unknown parameter is device power dissipation,  $P_{\rm D}$ . In calculating this parameter, the dissipation of the integrated circuit due to its own supply has to be considered, the dissipation within the package due to the external load must also be added. The power associated with the load in a dynamic (switching) situation must also be considered. For example, the power associated with an inductor or a capacitor in a static versus dynamic (say, 1 MHz) condition is significantly different.

The junction temperature of a device with a total package power of 600 mW at 70°C in a package with a thermal resistance of 63°C/W is 108°C:

$$T_J = 70^{\circ}C + (63^{\circ}C/W) \times (0.6W) = 108^{\circ}C$$

The next obvious question is, how safe is 108°C?

#### MAXIMUM ALLOWABLE JUNCTION TEMPERATURES

What is an acceptable maximum operating junction temperature is in itself somewhat of a difficult question to answer. Many companies have established their own standards based on corporate policy. However, the semi-conductor industry has developed some defacto standards based on the device package type. These have been well accepted as numbers that relate to reasonable (acceptable) device lifetimes, thus failure rates.

National Semiconductor has adopted these industry-wide standards. For devices fabricated in a molded package, the maximum allowable junction temperature is 150°C. For these devices assembled in ceramic or cavity DIP packages, the maximum allowable junction temperature is 175°C. The numbers are different because of the differences in package types. The thermal strain associated with the die package interface in a cavity package is much less than that exhibited in a molded package where the integrated circuit chip is in direct contact with the package material.

Let us use this new information and our thermal equation to construct a graph which displays the safe thermal (power) operating area for a given package type. Figure 5 is an example of such a graph. The end points of this graph are easily determined. For a 16-pin molded package, the maximum allowable temperature is 150°C; at this point no power dissipation is allowable. The power capability at 25°C is 1.98W as given by the following calculation:

$$P_D@25^{\circ}C = \frac{T_J(max) - T_A}{\theta_{JA}} = \frac{150^{\circ}C - 25^{\circ}C}{63^{\circ}C/W} = 1.98W$$

The slope of the straight line between these two points is minus the inversion of the thermal resistance. This is referred to as the derating factor.

Derating Factor = 
$$-\frac{1}{\theta_{JA}}$$

As mentioned, Figure 5 is a plot of the safe thermal operating area for a device in a 16-pin molded DIP. As long as the intersection of a vertical line defining the maximum ambient temperature (70°C in our previous example) and maximum device package power (600 mW) remains below the maximum package thermal capability line the junction temperature will remain below 150°C—the limit for a molded package. If the intersection of ambient temperature and package power fails on this line, the maximum junction temperature will be 150°C. Any intersection that occurs above this line will result in a junction temperature in excess of 150°C and is not an appropriate operating condition.

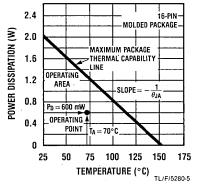


FIGURE 5. Package Power Capability vs Temperature

The thermal capabilities of all interface circuits are expressed as a power capability at 25°C still air environment with a given derating factor. This simply states, for every degree of ambient temperature rise above 25°C, reduce the package power capability stated by the derating factor which is expressed in mWl°C. For our example—a  $\theta_{\rm JA}$  of 63°C/W relates to a derating factor of 15.9 mWl°C.

# FACTORS INFLUENCING PACKAGE THERMAL RESISTANCE

As discussed earlier, improving any portion of the two primary thermal flow paths will result in an improvement in overall thermal resistance junction-to-ambient. This section discusses those components of thermal resistance that can be influenced by the manufacturer of the integrated circuit. It also discusses those factors in the overall thermal resistance that can be impacted by the end user of the integrated circuit. Understanding these issues will go a long way in understanding chip power capabilities and what can be done to insure the best possible operating conditions and, thus, best overall reliability.

#### Die Size

Figure 6 shows a graph of our 16-pin DIP thermal resistance as a function of integrated circuit die size. Clearly, as the chip size increases the thermal resistance decreases—this relates directly to having a larger area with which to dissipate a given power.

#### Lead Frame Material

Figure 7 shows the influence of lead frame material (both die attach and device pins) on thermal resistance. This graph compares our same 16-pin DIP with a copper lead frame, a Kovar lead frame, and finally an Alloy 42 type lead frame—these are lead frame materials commonly used in the industry. Obviously the thermal conductivity of the lead frame material has a significant impact in package power capability. Molded interface circuits from National Semiconductor use the copper lead frame exclusively.

#### **Board vs Socket Mount**

One of the major paths of dissipating energy generated by the integrated circuit is through the device leads. As a result of this, the graph of *Figure 8* comes as no surprise. This compares the thermal resistance of our 16-pin package soldered into a printed circuit board (board mount) compared to the same package placed in a socket (socket mount). Adding a socket in the path between the PC board and the device adds another stage in the thermal flow path, thus increasing the overall thermal resistance. The thermal capabilities of National Semiconductor's interface circuits are specified assuming board mount conditions. If the devices are placed in a socket the thermal capabilities should be reduced by approximately 5% to

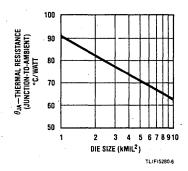


FIGURE 6. Thermal Resistance vs Die Size

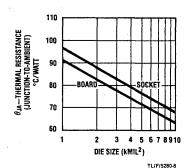


FIGURE 8. Thermal Resistance vs Board or Socket Mount

#### Air Flow

When a high power situation exists and the ambient temperature cannot be reduced, the next best thing is to provide air flow in the vicinity of the package. The graph of Figure 9 illustrates the impact this has on thermal resistance. This graph plots the relative reduction in thermal resistance normalized to the still air condition for our 16-pin molded DIP. The thermal ratings on National Semiconductor's interface circuits data sheets relate to the still air environment.

#### Other Factors

A number of other factors influence thermal resistance. The most important of these is using thermal epoxy in mounting ICs to the PC board and heat sinks. Generally these techniques are required only in the very highest of power applications.

Some confusion exists between the difference in thermal resistance junction-to-ambient  $(\theta_{JA})$  and thermal resistance junction-to-case  $(\theta_{JC})$ . The best measure of actual junction temperature is the junction-to-ambient number since nearly all systems operate in an open air environment. The only situation where thermal resistance junction-to-case is important is when the entire system is immersed in a thermal bath and the environmental temperature is indeed the case temperature. This is only used in extreme cases and is the exception to the rule and, for this reason, is not addressed in this application note.

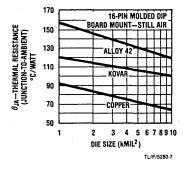


FIGURE 7. Thermal Resistance vs Lead Frame Material

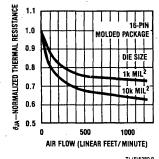


FIGURE 9. Thermal Resistance vs Air Flow

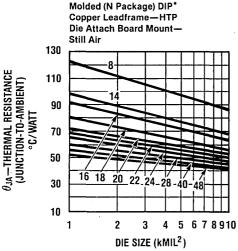
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#### NATIONAL SEMICONDUCTOR PACKAGE CAPABILITIES

Figures 10 and 11 show composite plots of the thermal characteristics of the most common package types in the National Semiconductor Interface Circuits product family. Figure 10 is a composite of the copper lead frame molded package. Figure 11 is a composite of the ceramic (cavity) DIP using poly die attach. These graphs represent board mount still air thermal capabilities. Another, and final, thermal resistance trend will be noticed in these graphs. As the number of device pins increase in a DIP the thermal resistance decreases. Referring back to the thermal flow chart, this trend should, by now, be obvious.

# **RATINGS ON INTERFACE CIRCUITS DATA SHEETS**

In conclusion, all National Semiconductor Interface Products define power dissipation (thermal) capability. This information can be found in the Absolute Maximum Ratings section of the data sheet. The thermal information shown in this application note represents average data for characterization of the indicated package. Actual thermal resistance can vary from  $\pm 10\%$  to  $\pm 15\%$  due to fluctuations in assembly quality, die shape, die thickness, distribution of heat sources on the die, etc. The numbers quoted in the interface data sheets reflect a 15% safety



\* Packages from 8 to 20-pin 0.3 mil width 22-pin 0.4 mil width 24 to 40-pin 0.6 mil width

FIGURE 10. Thermal Resistance vs Die Size vs Package Type (Molded Package)

margin from the average numbers found in this application note. Insuring that total package power remains under a specified level will guarantee that the maximum junction temperature will not exceed the package maximum.

The package power ratings are specified as a maximum power at 25°C ambient with an associated derating factor for ambient temperatures above 25°C. It is easy to determine the power capability at an elevated temperature. The power specified at 25°C should be reduced by the derating factor for every degree of ambient temperature above 25°C. For example, in a given product data sheet the following will be found:

Maximum Power Dissipation\* at 25°C

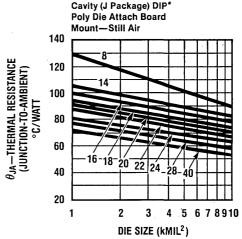
Cavity Package Molded Package

1509 mW 1476 mW

\*Derate cavity package at 10 mW/°C above 25°C; derate molded package at 11.8 mW/°C above 25°C.

If the molded package is used at a maximum ambient temperature of 70°C, the package power capability is 945 mW.

 $P_D @ 70^{\circ}C = 1476 \text{ mW} - (11.8 \text{ mW/}^{\circ}C) \times (70^{\circ}C - 25^{\circ}C)$ = 945 mW



\* Packages from 8 to 20-pin 0.3 mil width 22-pin 0.4 mil width 24 to 48-pin 0.6 mil width

TL/F/5280-11

FIGURE 11. Thermal Resistance vs Die Size vs Package Type (Cavity Package)

National Semiconductor
Semiconductor

# Industry Package Cross-Reference Guide

ı								
NSC	Signetics	Fairchild	Motorola	TI .	RCA	Silicon General	AMD	Raytheor
D	1	D	L		D	D	D	D, M
F	Q	F	F	F, S	. к	F	F	J, F,
н	Т, К, L, DB	н	G	L	S*, V1**	Т	н	т,
J	F	R,	U	J				DC, DD
к	DA	к	кs	к		к		K -LK, TK
N	V, A, B	Т,	P	P, N	E	M, N	PC	N, DN, DP, MP
	P F KC KC	NSC Signetics  D I  F Q  T, K, L, DB  K  KC DA	NSC Signetics Fairchild  D I D  F Q F  T, K, H L, DB  R, D  K  KC DA K	NSC Signetics Fairchild Motorola  I D L  F Q F F  T, K, L, DB  R, D  K S KC DA K KS  KC DA K K  N A, P	NSC Signetics Fairchild Motorola TI  D I D L  F Q F F F S  T, H G L DB R, D U J  K DA K K K K  KC DA K K K K	NSC         Signetics         Fairchild         Motorola         TI         RCA           D         I         D         L         D           F         Q         F         F         F, S         K           H         T, K, L, DB         H         G         L         S*, V1***           J         F         R, D         U         J           K         C         DA         K         K         K           N         V, T, P         P, N         E	NSC         Signetics         Fairchild         Motorola         TI         RCA         Silicon General           D         I         D         L         D         D         D           F         Q         F         F         F         K         F           H         T, K, L, DB         H         G         L         S*, V1**         T           J         F         R, D         U         J         K         K           K         C         DA         K         K         K         K           N         V, A, P         P         P, P, N         E         M, N	NSC         Signetics         Fairchild         Motorola         TI         RCA         Silicon General         AMD           D         I         D         L         D         D         D         D           F         Q         F         F         F         K         F         F           H         T, K, L, DB         H         G         L         S*, V1***         T         H           J         F         R, D         U         J         K         K         K           K         DA         K         K         K         K         K         K           N         A, P         P         P, N         E         M, N         PC

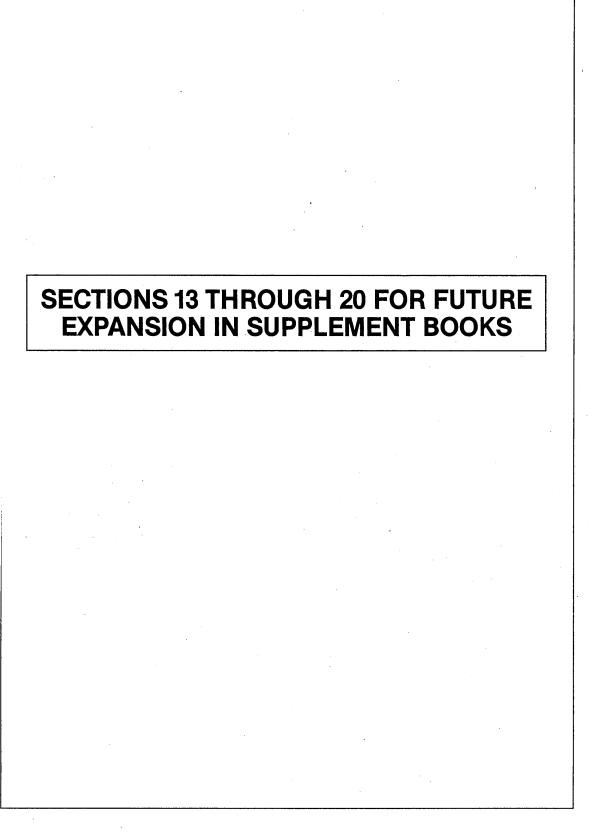
<sup>\*</sup>With dual-in-line formed leads.

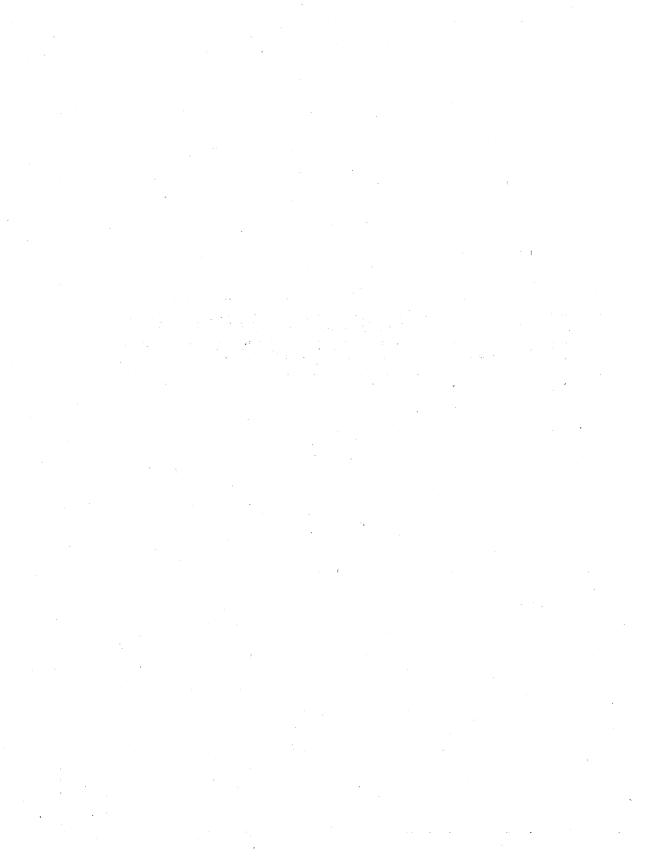
<sup>\*\*</sup>With radially formed leads.

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	NSC	Signetics	Fairchild	Motorola	TI ·	RCA	Silicon General	AMD	Raytheon
TO-202 (D-40, Durawatt)	P		,		КD				
"SGS" Type Power DIP	s		ВР	,					
TO-220	т	U	U		кс				
Low Temperature Glass Hermetic Flat Pack	w		F	F	w			FM	
TO-92 (Plastic)	z	S	w	P	ĹР				









# Section 21 Bipolar PROMs



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# Introduction

#### **GENERAL**

This generic Schottky PROM family by National Semiconductor makes available to the industry one of the widest selections in sizes and organizations. Four-bit wide PROMs are provided with 256 to 4096 words in pin compatible 16 and 18 pin dual-in-line packages. The 8-bit wide devices range from 32 to 4096 words in a variety of packages. Being 'generic,' all PROMs share a common programming algorithm.

#### TITANIUM-TUNGSTEN FUSES

National's new Programmable Read-Only Memories (PROMs) feature titanium-tungsten (Ti:W) fuse links designed to program efficiently with only 10.5 Volts applied. The high performance and reliability of these PROMs are the result of fabrication by a Schottky bipolar process, of which the titanium-tungsten metalization is an integral part, and the use of an on-chip programming circuit.

A major advantage of the titanium-tungsten fuse technology is the low programming voltage of the fuse links. At 10.5 Volts, this virtually eliminates the need for guard-ring devices and wide spacings required for other fuse technologies. Care is taken, however, to minimize voltage drops across the die and to reduce parasitics. The device is designed to ensure that worst-case fuse operating current is low enough for reliable long-term operation. The Darlington programming circuit is liberally designed to insure adequate power density for blowing the fuse links. The complete circuit design is optimized to provide high performance over the entire operating ranges of V<sub>CC</sub> and temperature.

#### **TESTABILITY**

The Schottky PROM die includes extra rows and columns of fusable links for testing the programmability of each chip. These test fuses are placed at the worst-case chip locations to provide the highest possible confidence in the programming tests in the final product. A ROM pattern is also permanently fixed in the additional circuitry and coded to provide a parity check of input address levels. These and other test circuits are used to test for correct operation of the row and column-select circuits and functionality of input and enable gates. All test circuits are available at both wafer and assembled device levels to allow 100% functional and parametric testing at every stage of the test flow.

### RELIABILITY

As with all National products, the Ti:W PROMs are subjected to an on-going reliability evaluation by the Reliability Assurance Department. These evaluations employ accelerated life tests, including dynamic high-temperature operating life, temperature-humidity life, temperature cycling, and thermal shock. To date, nearly 7.4 million Schottky Ti:W PROM device hours have been logged, with samples in Epoxy B molded DIP (N-package) and CERDIP (J-package). Device performance in all package configurations is excellent.

# **Bipolar PROM Selection Guide**

Size			DIP	Part	TAA	TEA	ıcc	Temperature
(Bits)	Organiz	ation	(Pins)	Number	(Max) in nS	(Max) in nS	(Max) in mA	Celsius
256	32 x 8	oc	16	DM54S188	45	30	110	-55 to +125
	32 x 8	oc	16	DM74S188	35	20	110	0 to +70
	32 x 8	TS	16	DM54S288	45	30	110	−55 to +125
	32 x 8	TS	16	DM74S288	35	20	110	0 to +70
1024	256 x 4	OC -	16	DM54S387	60	30	130	-55 to +125
	256 x 4	oc	. 16	DM74S387	50	25	130	0 to +70
	256 x 4	TS	16	DM54S287	60	30	130	−55 to +125
	256 x 4	TS	16	DM74S287	50	25	130	0 to +70
2048	512 x 4	ОС	16	DM54S570	65	35	130	-55 to +125
,	512 x 4	oc	16	DM74S570	55	30	130	0 to +70
	512 x 4	TS	16	DM54S571	65	35	130	-55 to +125
	512 x 4	TS	.16	DM74S571	55	30	130	0 to +70
	512 x 4	oc	16	DM54S570A	60	35	130	-55 to +125
	512 x 4	oc	16	DM74S570A	45	25	130	0 to +70
	512 x 4	TS	16	DM54S571A	60	35	130	-55 to +125
	512 x 4	TS	16	DM74S571A	45	25	130	0 to +70
	512 x 4	TS	16	DM54S571B	50	.35	130	-55 to +125
	512 x 4	TS	16	DM74S571B	35	25 ·	130	0 to +70
	256 x 8	TS	20	DM54LS471	70	35	100	-55 to +125
	256 x 8	TS	20	DM74LS471	60	30	100	0 to +70
4096	512 x 8	ОС	20	DM54S473	75	35	155	-55 to +125
	512 x 8	OC	20	DM74S473	60	30	155	0 to +70
	512 x 8	TS	20	DM54S472	75	35	155	-55 to +125
	512 x 8	TS	20	DM74S472	60	30	155	0 to +70
	512 x 8	OC	20	DM54S473A	60	35	155	-55 to +125
	512 x 8	OC	20	DM74S473A	45	25	155	0 to +70
	512 x 8	TS	· 20	DM54S472A	60	35	155	-55 to +125
	512 x 8	TS	20	DM74S472A	45	25	155	0 to +70
	512 x 8	TS	20	DM54S472B	50	35	155	-55 to +125
	512 x 8	TS	20	DM74S472B	35	25	155	0 to +70
	512 x 8	oc	24	DM54S475	75	40	170	-55 to +125
	512 x 8	oc	24	DM74S475	65	35	․ 170	0 to +70
	512 x 8	TS	24	DM54S474	75	40	170	-55 to +125
	512 x 8	TS	24	DM74S474	65	35	170	0 to +70
	512 x 8	oc	24	DM54S475A	60	35	170	-55 to +125
	512 x 8	oc	24	DM74S475A	45	25	170	0 to +70
	512 x 8	TS	24	DM54S474A	60	35	170	-55 to +125
	512 x 8	TS	24	DM74S474A	45	25	170	0 to +70
	512 x 8	TS	24	DM54S474B	50	35	170	-55 to +125
	512 x 8	TS	24	DM74S474B	35	25	170	0 to +70
	512×8	REG	24*	DM77SR474	40**	30	185	- 55 to + 125
	512×8	REG	24*	DM87SR474	35**	25	185	0 to +70
	512×8	REG	24*	DM77SR476	40**	30	185	- 55 to + 125
	512×8	REG	24*	DM77SR25	40**	30	185	-55 to +125
	512×8	REG	24*	DM87SR476	35**	25	185	0 to +70
	512×8	REG	24*	DM87SR25	35**	25	185	0 to +70
	1024 x 4	oc	18	DM54S572	75	45	140	-55 to +125
	1024 x 4	OC TO	18	DM74S572	60	35	140	0 to +70
	1024 x 4	TS	18	DM54S573	75 60	45 05	140	-55 to +125
*	1024 x 4	TS	18	DM74S573	60	35	140	0 to +70
	1024 x 4	oc	18	DM54S572A	60	35 95	140	-55 to +125
	1024 x 4	OC	18	DM74S572A	45	25	140	0 to +70
	1024 x 4	TS	18	DM54S573A	60	35	140	-55 to +125
	1024 x 4	TS	18	DM74S573A	45	25	140	0 to +70
	1024 x 4	TS	18	DM54S573B	50 25	35 05	140	-55 to +125
* 24	1024 x 4	TS v Dual I	18 nlina Da	DM74S573B	35	25	140	0 to +70

<sup>- 24</sup> Pin Narrow Dual Inline Package- Set up Time

# **Bipolar PROM Selection Guide**

Size (Bits)	Organiz	ation	DIP (Pins)	Part Number	TAA (Max) in nS	TEA (Max) in nS	ICC (Max) in mA	Temperature Celsius
8192	1024 x 8	ос	24	DM77S180	75	35	170	-55 to +125
	1024 x 8	TS	24*	DM77S280	75	35	170	-55 to +125
	1024 x 8	OC	24	DM87S180	55	30	170	0 to +70
	1024 x 8	TS	24*	DM87S280	55	30	170	0 to +70
	1024 x 8	OC	24	DM77S181	75	35	170	-55 to +125
	1024 x 8	TS	24*	DM77S281	75	35	170	-55 to +70
	1024 x 8	OC	24	DM87S181	55	30	170	0 to +70
	1024 x 8	TS	24*	DM87S281	55	30	170	0 to +70
	1024 x 8	TS	24	DM77LS181	175	70	100	-55 to +125
	1024 x 8	TS	24	DM87LS181	120	50	100	0 to +70
	1024 x 8	TS	24	DM77S181A	65	35	170	-55 to +125
	1024 x 8	TS	24	DM87S181A	45	30	170	0 to +70
	1024 x 8	REG.	24*	DM77SR181	50**	30 -	175	- 55 to + 125
	1024 x 8	REG.	24*	DM87SR181	40**	25	175	0 to +70
	2048 x 4	OC	- 18	DM77S184	75	35	140	-55 to +125
	2048 x 4	OC	18	DM87S184	55	30	140	0 to +70
	2048 x 4	TS	18	DM77S185	75	35	140	-55 to +125
	2048 x 4	TS	18	DM87S185	55	30	140	0 to +70
	2048 x 4	TS	18	DM77S185A	60	30	140	-55 to +125
	2048 x 4	TS	18	DM87S185A	45	25	140	0 to +70
	$2048 \times 4$	TS	18	DM77S185B	50	30	140	- 55 to + 125
	2048×4	TS	18	DM87S185B	35	25	140	0 to +70
16384	2048 x 8	ОС	24	DM77S190	80	40	175 ,	-55 to +125
	2048 x 8	TS	24*	DM77S290	80	40	175	-55 to +125
	2048 x 8	oc	24	DM87S190	65	30	175	0 to +70
	2048 x 8	TS	24*	DM87S290	65	30	175	0 to +70
	2048 x 8	oc	24	DM77S191	80	40	175	−55 to +125
	2048 x 8	TS	24*	DM77S291	80	40	175	−55 to +125
	2048 x 8	oc	24	DM87S191	65	30	175	0 to +70
	2048 x 8	TS	24*	DM87S291	65	30	175	0 to +70
	2048 x 8	TS	24	DM77S191A	60	35	175	-55 to +125
	2048 x 8	TS	24	DM87S191A	45	30	175	0 to +70
	2048 × 8	TS	24	DM77S191B	50	30	175	- 55 to + 125
	$2048 \times 8$	TS	24	DM87S191B	35	25	175	0 to +70
	$4096 \times 4$	TS	20	DM77S195A	60	30	170	- 55 to + 125
	$4096 \times 4$	TS	20	DM87S195A	45	25	170	0  to  + 70
	4096 × 4	TS	20	DM77S195B	50	30	170	- 55 to + 125
	4096 × 4	TS	20	DM87S195B	35	25	170	0 to +70
32768	4096 × 8	TS	24	DM77S321	65	35	185	-55 to +125
	4096 × 8	TS	24	DM87S321	55	30	185	0 to +70
	4096 × 8	TS	24*	DM77S421	65	35	185	- 55 to + 125
	$4096 \times 8$	TS	24*	DM87S421	55	30	185	0 to +70

# Absolute Maximum Ratings (Note 1)

 Supply Voltage (Note 2)
 -0.5 to +7.0V

 Input Voltage (Note 2)
 -1.2 to +5.5V

 Output Voltage (Note 2)
 -0.5 to +5.5V

 Storage Temperature
 -65 to +150C

 Lead Temperature (10 seconds)
 300C

# **Operating Conditions**

	Min	Max	Units
Supply Voltage (V <sub>CC</sub> )			
Military	4.50	5.50	V
Commercial	4.75	5.25	٧
Ambient Temperature (T <sub>A</sub> )			
Military	- 55	+ 125	°C
Commercial	0	+ 70	°C
Logical "0" Input Voltage	0	0.8	V
Logical "1" Input Voltage	2.0	5.5	٧

Note 1: Absolute maximum ratings are those values beyond which the device may be permanently damaged. They do not mean that the device may be operated at these values.

Note 2: These limits do not apply during programming. For the programming ratings, refer to the programming instructions.

<sup>\* -- 24</sup> Pin Narrow Dual Inline Package

<sup>\* -</sup> Set up Time

# **Bipolar PROMs**

# DM54/74S188, DM54/74S288 (32 X 8) 256-Bit TTL PROMs

# **General Description**

These Schottky memories are organized in the popular 32 words by 8 bits configuration. A memory enable input is provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 8 outputs go to the "OFF" or high impedance state. The memories are available in both open-collector and TRI-STATE® versions.

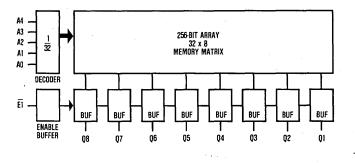
PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

# **Features**

- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access—22ns typ Enable access—15ns typ Enable recovery—15ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming

	Military	Commercial	Open- Collector	TRI-STATE	Package
DM74S188		Х	Х		N,J
DM74S288		Х		×	N,J
DM54S188	Х		Х		J
DM54S288	X			Х	J

# **Block and Connection Diagram**



Order Number; DM74S188 J, DM74S288 J, DM54S188 J, DM54S288 J See NS Package J16A

16 V<sub>CC</sub> ĒĪ Q2 **A4** Q3 A3 Q4 A2 6 Q6 A1 7 10 Q7 AO 8 08 GND

Order Number; DM74S188 N or DM74S288 N See NS Package N16A

n	$\mathbf{C}$	Floctri	cal	Charac	teristics	(Note 2)
u				CHAIAC.	16.112.111.2	TIVOTE 31

C	Downston	Conditions	DM	545188	/288	DM	745188	/288	11-24-
Sym	Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
I <sub>IL</sub>	Input Load Current	$V_{CC} = Max$ , $V_{IN} = 0.45V$		-80	-250		-80	-250	μА
I <sub>IH</sub>	Input Leakage Current	$V_{CC} = Max$ , $V_{IN} = 2.7V$			25			25	μА
		$V_{CC} = Max$ , $V_{IN} = 5.5V$			1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC} = Min, I_{OL} = 16mA$		0.35	0.50		0.35	0.45	V
V <sub>IL</sub>	Low Level Input Voltage				0.80			0.80	V
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0			V
loz	Output Leakage Current	$V_{CC} = Max, V_{CEX} = 2.4V$			50		]	50	μΑ
	(Open-Collector Only)	V <sub>CC</sub> = Max, V <sub>CEX</sub> = 5.5V			100			100	μΑ
V <sub>C</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18mA		-0.8	-1.2		-0.8	-1.2	V
Cı	Input Capacitance	$V_{CC} = 5.0, V_{IN} = 2.0V$		4.0			4.0		pF
	, i	$T_A = 25C$ , 1MHz	1						
Co	Output Capacitance	$V_{CC} = 5.0V$ , $V_O = 2.0V$ $T_A = 25C$ , 1MHz, Outputs Off		6.0			6.0		pF.
lcc	Power Supply Current	V <sub>CC</sub> = Max, Inputs Grounded All Outputs Open		70	110		70	110	mA
TRI-	STATE® Parameters								
los	Short Circuit Output Current	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max (Note 4)	-20		-70	-20		-70	mA
loz	Output Leakage	$V_{CC} = Max$ , $V_{O} = 0.45$ to 2.4V			+50			+50	μА
	(TRI-STATE)	Chip Disabled			-50			-50	μА
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = -2.0mA	2.4	3.2					V
		$I_{OH} = -6.5$ mA	<u> </u>		<u> </u>	2.4	3.2		V

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

Sym	Parameter	JEDEC Symbol	DM54S188/288		DM74S188/288			Units	
	i didirecti	JEDEC Symbol	Min	Тур	Max	Min	Тур	Max	Office
TAA	Address Access Time	TAVQV		22	45		22	35	ns
TEA	Enable Access Time	TEVQV		15	30		15	20	ns
TER	Enable Recovery Time	TEXQX		15	35		15	25	ns
TZX	Output Enable Time	TEVQX		15	30		15	20	ns
TXZ	Output Disable Time	TEXQZ		15	35		15	25	ns

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25C$ .

Note 4: During I<sub>OS</sub> measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

# National Semiconductor DM54/74S387, DM54/74S

# **Bipolar PROMs**

# DM54/74S387, DM54/74S287 (256 X 4) 1024-Bit TTL PROMs

#### **General Description**

These Schottky memories are organized in the popular 256 words by 4 bits configuration. Memory enable inputs are provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 4 outputs go to the "OFF" or high impedance state. The memories are available in both open-collector and TRI-STATE® versions.

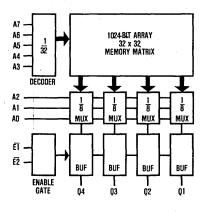
PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

#### **Features**

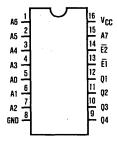
- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access—35ns typ Enable access—15ns typ Enable recovery—15ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming

*	Military	Commercial	Open- Collector	TRI-STATE	Package
DM74S387		Х	· X		N,J
DM74S287		Х		Х	N,J
DM54S387	Х		Х		J
DM54S287	X			Х	J

### **Block and Connection Diagram**



Order Number; DM74S387 J, DM74S287 J, DM54S387 J, DM54S287 J See NS Package J16A



Order Number; DM74S387 N or DM74S287 N See NS Package N16A

DC	Electri	cal Cha	aracter	eniteir	(Note 3)
-	LICCIII	cai Cii	וטטנכו	เอแบอ	HNOLE 31

	Downwater	Conditions	DM	545387	/287	DM	74S387	Units	
Sym	Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
I <sub>IL</sub>	Input Load Current	$V_{CC} = Max, V_{IN} = 0.45V$	1	-80	-250		-80	-250	μΑ
l <sub>IH</sub>	Input Leakage Current	$V_{CC} = Max$ , $V_{IN} = 2.7V$			25			25	μΑ
		$V_{CC} = Max, V_{IN} = 5.5V$			1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16mA		0.35	0.50		0.35	0.45	V
V <sub>IL</sub>	Low Level Input Voltage				0.80	l		0.80	V
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0			V
l <sub>OZ</sub>	Output Leakage Current	$V_{CC} = Max, V_{CEX} = 2.4V$			50			50	μΑ
	(Open-Collector Only)	$V_{CC} = Max, V_{CEX} = 5.5V$			100			100	μΑ
$V_{C}$	Input Clamp Voltage	$V_{CC} = Min, I_{IN} = -18mA$		-0.8	-1.2		-0.8	-1.2	V
С	Input Capacitance	$V_{CC} = 5.0$ , $V_{IN} = 2.0V$ $T_A = 25C$ , 1MHz		4.0			4.0		pF
Со	Output Capacitance	$V_{CC} = 5.0V, V_{O} = 2.0V$		6.0			6.0		pF
		T <sub>A</sub> = 25C, 1MHz, Outputs Off		İ					
lcc	Power Supply Current	V <sub>CC</sub> = Max, Inputs Grounded All Outputs Open		80	130		80	130	mA
TRI-	STATE® Parameters								
los	Short Circuit Output Current	$V_O = 0V$ , $V_{CC} = Max$ (Note 4)	-20		-70	-20	!	-70	mA
loz	Output Leakage	$V_{CC} = Max, V_O = 0.45 \text{ to } 2.4V$			+50			+50	μΑ
	(TRI-STATE)	Chip Disabled			50			-50	μΑ
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = -2.0mA	2.4	3.2					V
		I <sub>OH</sub> = 6.5mA				2.4	3.2		V

## AC Electrical Characteristics (With Standard Load and Operating Conditions)

Sym	Parameter	JEDEC Symbol	DM:	DM54S387/287			74S387	Units	
Sym	Palantelei	JEDEC Symbol	Min	Тур	Max	Min	Тур	Max	Offics
TAA	Address Access Time	TAVQV	<b>†</b>	35	60		35	50	ns
TEA	Enable Access Time	TEVQV		15	30		15	25	ns
TER	Enable Recovery Time	TEXQX		15	30		15	25	ns
TZX	Output Enable Time	TEVQX		15	30		15	25	ns
TXZ	Output Disable Time	TEXQZ		15	30		15	25	ns

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25C$ .

Note 4: During I<sub>OS</sub> measurement, only one output at a time should be grounded. Permanent damage may otherwise result.



# DM54/74S570, DM54/74S571; DM54/74S570A, DM54/74S571A; DM54/74S571B (512 × 4) 2048-Bit TTL PROMs

### **General Description**

These Schottky memories are organized in the popular 512 words by 4 bits configuration. A memory enable input is provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 4 outputs go to the "OFF" or high impedance state. The memories are available in both open-collector and TRI-STATE® versions.

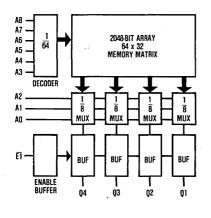
PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

#### **Features**

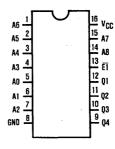
- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access—30ns typ Enable access—15ns typ Enable recovery—15ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming

	Military	Commercial	Open- Collector	TRI-STATE	Package
DM74S570		×	х		N,J
DM74S571		Х		X	N,J
DM54S570	X		Х		J
DM54S571	X			Х	J

#### **Block and Connection Diagram**



Order Number; DM74S570 J, DM74S571 J, DM54S570 J, or DM54S571 J See NS Package J16A



Order Number; DM74S570 N or DM74S571 N See NS Package N16A

C	Danamatar	Conditions	DM	DM54S570/571			74S570	Units	
IIL Input Lo  IIH Input Le  VoL Low Lev  VIL Low Lev  VIH High Lev  (Open-C  VC Input Cl  C1 Input Ca	Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
կլ∟	Input Load Current	$V_{CC} = Max$ , $V_{IN} = 0.45V$		-80	-250		-80	-250	μΑ
I <sub>IH</sub>	Input Leakage Current	$V_{CC} = Max, V_{IN} = 2.7V$			25			25	μA
		$V_{CC} = Max, V_{IN} = 5.5V$			1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16mA		0.35	0.50		0.35	0.45	V
VIL	Low Level Input Voltage				0.80			0.80	V
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0			V
loz	Output Leakage Current	$V_{CC} = Max, V_{CEX} = 2.4V$			50			50	μΑ
	(Open-Collector Only)	$V_{CC} = Max, V_{CEX} = 5.5V$			100			100	μΑ
V <sub>C</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18mA		-0.8	-1.2		-0.8	-1.2	V
Cı	Input Capacitance	$V_{CC} = 5.0, V_{IN} = 2.0V$		4.0			4.0		pF
		T <sub>A</sub> = 25C, 1MHz							· •
Co	Output Capacitance	$V_{CC} = 5.0V$ , $V_O = 2.0V$ $T_A = 25C$ , 1MHz, Outputs Off		6.0			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max, Inputs Grounded All Outputs Open		90	130	,	90	130	mA

#### TRI-STATE® Parameters

los	Short Circuit Output Current	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max (Note 4)	-20		-70	-20		-70	mA	
loz	Output Leakage	$V_{CC} = Max$ , $V_{O} = 0.45$ to 2.4V			+50			+50	μΑ	
	(TRI-STATE)	Chip Disabled			-50			-50	μΑ	
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = -2.0mA	2.4	3.2					V	
		I <sub>OH</sub> = 6.5mA				2.4	3.2		V	

## AC Electrical Characteristics (With Standard Load and Operating Conditions)

Sym	Parameter	JEDEC Symbol	DM54S570/571			DM	748570	Units	
		orbro cymbol	Min	Тур	Max	Min	Тур	Max	01112
TAA	Address Access Time	TAVQV		40	65		40	55	ns
TEA	Enable Access Time	TEVQV		20	35	-	20	30	ns ·
TER	Enable Recovery Time	TEXQX		20	35		20	30	ns
TZX	Output Enable Time	TEVQX ·		20	35		20	30	ns
TXZ	Output Disable Time	TEXQZ		20	35		20	30	ns

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

C	Davamatas	Parameter JEDEC Symbol		DM54S571A, B/570A			DM7	Units		
Sym	raiametei			Min	Тур	Max	Min	Тур	Max	Units
TAA	Address Access Time	TAVQV	571A/570A		30	60		30	45	ns
			571B		30	50		30	35	ns
TEA	Enable Access Time	TEVQV			15	35		15	25	ns
TER	Enable Recovery Time	TEXQX			15	35		15	25	ns
TZX	Output Enable Time	TEVQX			15	35		15	25	ns
TXZ	Output Disable Time	TEXQZ			15	35		15	25	ns

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25C$ .

Note 4: During IOS measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

# National Semiconductor

# **Bipolar PROMs**

# DM54/74LS471 (256 X 8) 2048-Bit TTL PROMs

#### **General Description**

These Schottky memories are organized in the popular 256 words by 8 bits configuration. Memory enable inputs are provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 8 outputs go to the "OFF" or high impedance state.

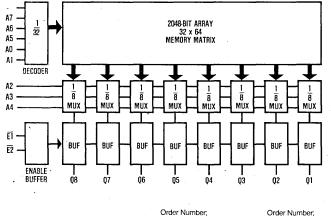
PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

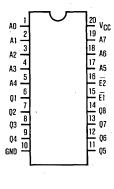
#### **Features**

- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access—40ns typ Enable access—15ns typ Enable recovery—15ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming

	Military	Commercial	Open- Collector	TRI-STATE	Package
DM74LS471		X	,	Х	N,J
DM54LS471	Х			X	J

# **Block and Connection Diagram**





DM74LS471 J, DM54LS471 J, DM54LS471 J, See NS Package J20B Order Number; DM74LS471 N See NS Package N20A

0	Downwater	Conditions	Di	VI54LS4	171	DI	M74LS4	171	Units
Sym	Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
IIL	Input Load Current	$V_{CC} = Max, V_{IN} = 0.45V$		-80	-250		-80	-250	μА
I <sub>IH</sub>	Input Leakage Current	$V_{CC} = Max, V_{IN} = 2.7V$			25			25	μΑ
		$V_{CC} = Max$ , $V_{IN} = 5.5V$		Ī	1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16mA		0.35	0.50		0.35	0.45	V
V <sub>IL</sub>	Low Level Input Voltage				0.80			0.80	V
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0			V
V <sub>C</sub>	Input Clamp Voltage	$V_{CC} = Min, I_{IN} = -18mA$		-0.8	-1.2		-0.8	-1.2	V
Cı	Input Capacitance	$V_{CC} = 5.0$ , $V_{IN} = 2.0V$ $T_A = 25C$ , 1MHz		4.0			4.0		pF
Co	Output Capacitance	$V_{CC} = 5.0V$ , $V_O = 2.0V$ $T_A = 25C$ , 1MHz, Outputs Off		6.0			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max, Inputs Grounded All Outputs Open		75	100		75	100	mA

#### TRI-STATE® Parameters

los	Short Circuit Output Current	$V_O = 0V$ , $V_{CC} = Max$ (Note 4)	-20		-70	-20		-70	mA
loz	Output Leakage	$V_{CC} = Max, V_O = 0.45 \text{ to } 2.4V$			+50			-+50	μΑ
	(TRI-STATE)	Chip Disabled			-50			-50	μА
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = -2.0mA	2.4	3.2					V.
		I <sub>OH</sub> = 6.5mA				2.4	3.2		V

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

Sym	Parameter	JEDEC Symbol	D	D	M74LS4	Units			
Sylli	raianielei	JEDEC Symbol	Min	Тур	Max	Min	Тур	Max	Offics
TAA	Address Access Time	TAVQV		45	70		40	60	ns
TEA	Enable Access Time	TEVQV		15	35		15	30	ns
TER	Enable Recovery Time	TEXQX		15	35		15	30	ns
TZX	Output Enable Time	TEVQX		15	35		15	30	ns
TXZ	Output Disable Time	TEXQZ		15	35		15	30	ns

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25C$ .

Note 4: During I<sub>OS</sub> measurement, only one output at a time should be grounded. Permanent damage may otherwise result.



VCC

8A

A7 A6

A5 ĒĪ

08

**Q7** 

**Q6** 

05

11

# DM54/74S473, DM54/74S472; DM54/74S473A, DM54/74S472A; DM54/74S472B (512 × 8) 4096-Bit TTL PROMs

#### **General Description**

These Schottky memories are organized in the popular 512 words by 8 bits configuration. A memory enable input is provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 8 outputs go to the "OFF" or high impedance state. The memories are available in both open-collector and TRI-STATE® versions.

PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

#### **Features**

- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access—25ns typ Enable access—15ns typ Enable recovery—15ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature

A3

Q2

Q3

GND

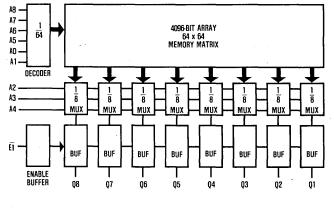
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■ Low voltage TRI-SAFE<sup>TM</sup> programming

	Military	Commercial	Open- Collector	TRI-STATE	Package
DM74S473		X	Х		N,J
DM74S472		X		Х	N,J
DM54S473	Х		Х		J
DM54S472	Х			Х	J

## **Block and Connection Diagram**



Order Number; DM74S473 J, DM74S472 J, DM54S473 J, or DM54S472 J See NS Package J20B Order Number; DM74S473 N or DM74S472 N See NS Package N20A

C	Power-rate -	Conditions	DM54S473/472			DM74S473/472			11
Sym	Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
I <sub>IL</sub>	Input Load Current	$V_{CC} = Max$ , $V_{IN} = 0.45V$		-80	-250		-80	-250	μА
lн	Input Leakage Current	$V_{CC} = Max, V_{IN} = 2.7V$			25			25	μΑ
		V <sub>CC</sub> = Max, V <sub>IN</sub> = 5.5V			1.0			1.0	mA
VOL	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16mA		0.35	0.50		0.35	0.45	٧
V <sub>IL</sub>	Low Level Input Voltage				0.80			0.80	V
V <sub>iH</sub>	High Level Input Voltage		2.0			2.0			٧
loz	Output Leakage Current	$V_{CC} = Max, V_{CEX} = 2.4V$			50			50	μΑ
	(Open-Collector Only)	$V_{CC} = Max, V_{CEX} = 5.5V$			100			100	μА
V <sub>C</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18mA		-0.8	-1.2		-0.8	-1.2	V
C <sub>I</sub>	Input Capacitance	$V_{CC} = 5.0, V_{IN} = 2.0V$		4.0			4.0		pF
		T <sub>A</sub> = 25C, 1MHz				·			
Co	Output Capacitance	$V_{CC} = 5.0V$ , $V_{O} = 2.0V$ $T_{A} = 25C$ , 1MHz, Outputs Off		6.0			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max, Inputs Grounded All Outputs Open		110	155		110	155	mA
TRI-	STATE® Parameters			-					
los	Short Circuit Output Current	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max (Note 4)	-20		-70	-20		-70	mA
loz	Output Leakage	$V_{CC} = Max, V_O = 0.45 \text{ to } 2.4V$			+50			+50	μΑ
	(TRI-STATE)	Chip Disabled			-50			-50	μΑ
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = -2.0mA	2.4	3.2					٧
		I <sub>OH</sub> = 6.5mA				2.4	3.2		V

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

Sym	Parameter	JEDEC Symbol	DM54S473/472			DM74S473/472			Units
Sylli	raidifietes	JEDEC Symbol	Min . T	Тур	Max	Min	Тур	Max	Offics
TAA	Address Access Time	TAVQV		40	75		40	60	ns
TEA	Enable Access Time	TEVQV		15	35		15	30	ns
TER	Enable Recovery Time	TEXQX		15	35		15	30	ns
TZX	Output Enable Time	TEVQX		15	35		15	30	ns
TXZ	Output Disable Time	TEXQZ		15	35		15	30	ns

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

C	Parameter	1505	0.0	DM5	4S473A/47	2A, B	DM7	2A, B	Units	
Sym	Faiailleter	JEDE	C Symbol	Min	Тур	Max	Min	Тур	Max	Units
TAA	Address Access Time	TAVQV	473A/472A		25	60		25	45	ns
			472B		25	50		25	35	ns
TEA	Enable Access Time	TEVQV	473A/472A		15	35		15	30	ns
			472B		15	35		15	25	ns
TER	Enable Recovery Time	TEXQX	473A/472A		15	35		15.	30	ns
			472B		15	35		15	25	ns
TZX	Output Enable Time	TEVQX	473A/472A		15	35		15	30	ns
			472B		15	35		15	25	ns
TXZ	Output Disable Time	TEXQZ	473A/472A		15	35		15	30	ns
		Į.	472B		15	35		15	25	ns

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for V<sub>CC</sub> = 5.0V and T<sub>A</sub> = 25C.

Note 4: During I<sub>OS</sub> measurement, only one output at a time should be grounded. Permanent damage may otherwise result.



# DM54/74S475, DM54/74S474; DM54/74S475A, DM54/74S474A; DM54/74S474B (512 × 8) 4096-Bit TTL PROMs

#### **General Description**

These Schottky memories are organized in the popular 512 words by 8 bits configuration. Memory enable inputs are provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 8 outputs go to the "OFF" or high impedance state. The memories are available in both open-collector and TRI-STATE® versions.

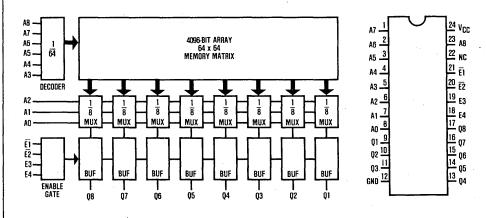
PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

#### **Features**

- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access—25ns typ Enable access—15ns typ Enable recovery—15ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming

	Military	Commercial	Open- Collector	TRI-STATE	Package
DM74S475		x	×		N,J
DM74S474		Х	, , , , , , ,	X	N,J
DM54S475	Х		X		J
DM54S474	Х			X	J

#### **Block and Connection Diagram**



Order Number: DM74S475 J, DM74S474 J, DM54S475 J, or DM54S474 J See NS Package J24A Order Number: DM74S475 N or DM74S474 N See NS Package N24A

		0	DM	54\$475	5/474	DM	6/474		
Sym	Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
I <sub>IL</sub>	Input Load Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.45V		-80	-250		-80	-250	μА
I <sub>IH</sub>	Input Leakage Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 2.7V			· 25			25	μА
		$V_{CC} = Max$ , $V_{IN} = 5.5V$			1.0			1.0	mA
VOL	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16mA		0.35	0.50		0.35	0.45	V
V <sub>IL</sub>	Low Level Input Voltage	·			0.80			0.80	V
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0			V
loz	Output Leakage Current	V <sub>CC</sub> = Max, V <sub>CEX</sub> = 2.4V			50			50	μΑ
	(Open-Collector Only)	V <sub>CC</sub> = Max, V <sub>CEX</sub> = 5.5V			100			100	μА
V <sub>C</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18mA		-0.8	-1.2		-0.8	-1.2	٧
Cı	Input Capacitance	V <sub>CC</sub> = 5.0, V <sub>IN</sub> = 2.0V		4.0			4.0		pF
		T <sub>A</sub> = 25C, 1MHz				<u>                                      </u>			
Co	Output Capacitance	$V_{CC} = 5.0V$ , $V_O = 2.0V$ $T_A = 25C$ , 1MHz, Outputs Off		6.0			6.0		pF
lcc	Power Supply Current	V <sub>CC</sub> = Max, Inputs Grounded All Outputs Open		115	170		115	170	mA
TRI-	STATE® Parameters								
los	Short Circuit Output Current	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max (Note 4)	-20		-70	-20		-70	mA
loz	Output Leakage	$V_{CC} = Max, V_O = 0.45 \text{ to } 2.4V$			+50			+50	μА
	(TRI-STATE)	Chip Disabled		-	-50			-50	μА
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = -2.0mA	2.4	3.2					V
		I <sub>OH</sub> = 6.5mA				2.4	3.2		V

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

Sym	Parameter	JEDEC Symbol	DM54\$475/474			DM	74\$475	Units	
	raidificiei	oedec symbol	Min	Тур	Max	Min	Тур	Max	Onics
TAA	Address Access Time	TAVQV		40	·75		40	65	ns
TEA	Enable Access Time	TEVQV		20	40		20	35	ns
TER	Enable Recovery Time	TEXQX		20	40	1	20	35	ns
	Output Enable Time	TEVQX		20	40		20	35	ns
TXZ	Output Disable Time	TEXQZ		20	40		20	35	ns

## AC Electrical Characteristics (With Standard Load and Operating Conditions)

C	Baramatar.	150500		DM54S475A/474A, B			DM7	4A, B			
Sym	Parameter	JEDE	C Symbol	Min	Тур	Max	Min	Тур	Max	Units	
TAA	Address Access Time	TAVQV	475A/474A		25	60		25	45	ns	
		]	474B		25	50		25	35	ns	
TEA	Enable Access Time	TEVQV			15	35		15	25	'ns	
TER	Enable Recovery Time	TEXQX			15	35		15	25	ns	
TZX	Output Enable Time	TEVQX			15	35		15	25	ns	
TXZ	Output Disable Time	TEXQZ			15	35		15	25	ns	

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25C$ .

Note 4: During I<sub>OS</sub> measurement, only one output at a time should be grounded. Permanent damage may otherwise result.



# Bipolar PROMs PRELIMINARY

# DM77/87SR474, DM77/87SR474B (512 $\times$ 8) 4k-Bit Registered TTL PROM

#### **General Description**

The DM77/87SR474 is an electrically programmable Schottky TTL read-only memory with D-type, masterslave registers on-chip. This device is organized as 512 words by 8-bits and is available in the TRI-STATE® output version. Designed to optimize system performance, this device also substantially reduces the cost and size of pipelined microprogrammed systems and other designs wherein accessed PROM data is temporarily stored in a register. The DM77/87SR474 also offers maximal flexibility for memory expansion and data bus control by providing both synchronous and asynchronous output enables. All outputs will go into the "OFF" state if the synchronous chip enable (GS) is high before the rising edge of the clock, or if the asynchronous chip enable (G) is held high. The outputs are enabled when GS is brought low before the rising edge of the clock and  $\overline{G}$  is held low. The GS flip-flop is designed to power up to the "OFF" state with the application of V<sub>CC</sub>.

Data is read from the PROM by first applying an address to inputs A0-A8. During the setup time the output of the array is loaded into the master flip-flop of the data register. During the rising edge (low to high transition) of the clock, the data is then transferred to the slave of the flip-flop and will appear on the output if the output is enabled. Following the rising edge clock transition the addresses and synchronous chip enable can be removed and the output data will remain stable.

TRI-STATE® is a registered trademark of National Semiconductor Corp. TRI-SAFETM is a trademark of National Semiconductor Corp.

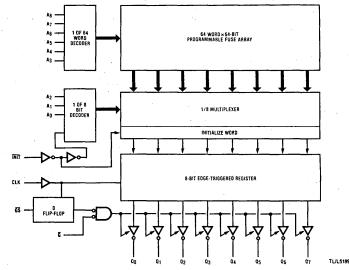
The DM77/87SR474 also features an initialize function, INIT. The initialize function provides the user with an extra word of programmable memory which is accessed with single pin control by applying a low on INIT. The initialize function is synchronous and is loaded into the output register on the next rising edge of the clock. The unprogrammed state of the INIT is all lows, providing a CLEAR function when not programmed.

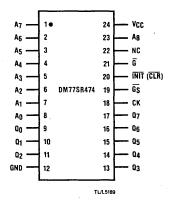
PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions. Once programmed, it is impossible to go back to a low.

#### **Features**

- On-chip, edge-triggered registers
- Synchronous and asynchronous enables for word expansion
- Programmable synchronous register INITIALIZE
- 24-pin, 300 mil thin-dip package
- 35ns address setup and 20ns clock to output for maximum system speed
- Highly reliable, titanium tungsten fuses
- TRI-STATE outputs
- Low voltage TRI-SAFETM programming
- All parameters guaranteed over temperature
- Pinout compatible with DM77SR181 (1k×8)
  Registered PROM for future expansion

# **Block and Connection Diagrams**





Order Number DM77SR474J, DM87SR474J, DM87SR474N, DM77SR474BJ, DM87SR474BJ or DM87SR474BN See NS Package J24F or N24C

\_\_\_\_

Cumbal	Description	04111	DN	177SR4	174	· Dr	187SR	174	limia.
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Min.	Тур.	Max.	Units
l <sub>IL</sub>	Input Load Current	$V_{CC} = Max., V_{IN} = 0.45V$		-80	-250		-80	-250	μΑ
,	Input Leakage Current	$V_{CC} = Max., V_{IN} = 2.7V$			25			25	μΑ
Iн	input Leakage Current	$V_{CC} = Max., V_{IN} = 5.5 V$			1.0			1.0	mA
$V_{OL}$	Low Level Output Voltage	$V_{CC} = Min., I_{OL} = 16mA$		0.35	0.50		0.35	0.45	٧
VIL	Low Level Input Voltage				0.80			0.80	٧
$V_{IH}$	High Level Input Voltage		2.0			2.0			٧
loz	Output Leakage Current	$V_{CC} = Max., V_{CEX} = 2.4V$			- 50			50	μΑ
V <sub>C</sub>	Input Clamp Voltage	$V_{CC} = Min., I_{IN} = -18mA$		-0.8	-1.2		-0.8	-1.2	٧
Cı	Input Capacitance	$V_{CC} = 5.0$ , $V_{IN} = 2.0$ V $T_A = 25$ °C, 1 MHz		4.0			4.0		pF
Co	Output Capacitance	$V_{CC} = 5.0 \text{ V}, V_O = 2.0 \text{ V}$ $T_A = 25^{\circ}\text{C}, 1 \text{ MHz}, \text{ Outputs Off}$		6.0			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max., Inputs Grounded All Outputs Open		135	185		135	185	mA
	TRI-STATE Parameters								
los	Short Circuit Output Current	$V_O = 0V$ , $V_{CC} = Max$ . (Note 4)	-20		-70	-20		-70	mA
loz	Output Leakage (TRI-STATE)	$V_{CC} = Max., V_O = 0.45 \text{ to } 2.4V$ Chip Disabled	-50		+50	-50	-	+50	μА
		I <sub>OH</sub> = -2.0mA	2.4	3.2					V
$V_{OH}$	Output Voltage High	I <sub>OH</sub> = -6.5mA	1			2.4	3.2		V

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for V<sub>CC</sub> = 5.0V and T<sub>A</sub> = 25°C.

Note 4: During IOS measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

# **Switching Characteristics**

·	<u> </u>			DI	M77SR4	174	DI	V187SR	474	
Symbol	Parameter			Min.	Тур.	Max.	Min.	Тур.	Max.	Unit
	Address to CLK (High) Setup Time	SR474		55	20		50	20		ns
t <sub>S(A)</sub>	Address to CLK (High) Setup Time	SR474	В	40	20		35	20		115
t <sub>H(A)</sub>	Address to CLK (High) Hold Time			0	-5		0	-5		ns
t <sub>S(ĪNĪT)</sub>	INIT to CLK (High) Setup Time			30	20		25	20		ns
t <sub>H(INIT)</sub>	INIT to CLK (High) Hold Time			0	-5		0	-5		ns
t <sub>PHL(CLK)</sub>	Delay from CLK (High) to Output (High or I	l ow)	SR474		15	30		15	27	ns
tplh(CLK)	Delay from Ock (riigh) to Output (riigh of t	nay nom out (mgn) to output (mgn of 200)		ļ	15	25		15	20	113
twh(CLK)	CLK Width (High or Low)		25	13		20	13		ns	
t <sub>S(GS)</sub>	GS to CLK (High) Setup Time			10	0		10	0		ns
t <sub>H(GS)</sub>	GS to CLK (High) Hold Time			5	0		5	0		ns
t <sub>PZL(CLK)</sub>	Delay from CLK (High) to Output Active (H	igh or	Low)		20	35		20	30	ns
$t_{PZL(\overline{G})}$ $t_{PZH(\overline{G})}$	Delay from $\overline{G}$ (Low) to Output Active (High	or Lo	w)		15	30		15	25	ns
t <sub>PLZ(CLK)</sub> t <sub>PHZ(CLK)</sub>	Delay from CLK (High) to Output Inactive (TRI-STATE)				20	35		20	30	ns
t <sub>PLZ(G)</sub> t <sub>PHZ(G)</sub>	Delay from $\overline{G}$ (Low) to Output Inactive (TRI-STATE)				15	30		15	25	ns

# **Bipolar PROMs PRELIMINARY**

# DM77/87SR476, DM77/87SR25, DM77/87SR476B, DM77/87SR25B (512 × 8) 4k-Bit Registered TTL PROM

#### **General Description**

The DM77/87SR476 is an electrically programmable Schottky TTL read-only memory with D-type, masterslave registers on-chip. This device is organized as 512 words by 8-bits and is available in the TRI-STATE® output version. Designed to optimize system performance, this device also substantially reduces the cost and size of pipelined microprogrammed systems and other designs wherein accessed PROM data is temporarily stored in a register. The DM77/87SR476 also offers maximal flexibility for memory expansion and data bus control by providing both synchronous and asynchronous output enables. All outputs will go into the "OFF" state if the synchronous chip enable (GS) is high before the rising edge of the clock, or if the asynchronous chip enable (G) is held high. The outputs are enabled when GS is brought low before the rising edge of the clock and  $\overline{G}$  is held low. The GS flip-flop is designed to power up to the "OFF" state with the application of V<sub>CC</sub>.

Data is read from the PROM by first applying an address to inputs A0-A8. During the setup time the output of the array is loaded into the master flip-flop of the data register. During the rising edge (low to high transition) of the clock, the data is then transferred to the slave of the flipflop and will appear on the output if the output is enabled. Following the rising edge clock transition the addresses and synchronous chip enable can be removed and the output data will remain stable.

The DM77SR476 also features an initialize function, INIT.

TRI-STATE® is a registered trademark of National Semiconductor Corp. TRI-SAFETM is a trademark of National Semiconductor Corp.

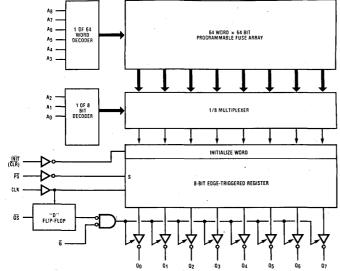
The initialize function provides the user with an extra word of programmable memory which is accessed with single pin control by applying a low on INIT. The initialize function is asynchronous and is loaded into the output register when INIT is brought low. The unprogrammed state of the INIT is all lows, which makes it compatible with the CLEAR function on the AM27S25. PS loads ones into the output registers when brought low.

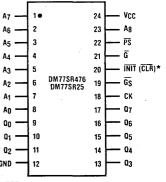
PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions. Once programmed, it is impossible to go back to a low.

#### **Features**

- Functionally compatible with AM27S25
- On-chip, edge-triggered registers
- Synchronous and asynchronous enables for word expansion
- Programmable asynchronous INITIALIZE (SR476 only)
- 24-pin, 300 mil thin-dip package
- 35ns address setup and 20ns clock to output for maximum system speed
- Highly reliable, titanium tungsten fuses
- TRI-STATE outputs
- Low voltage TRI-SAFE<sup>TM</sup> programming
- All parameters guaranteed over temperature
- Preset input

# **Block and Connection Diagrams**





\* CLR only on DM77/87SR25

Order Number DM77SR476J. DM77SR25J, DM77/87SR476N, DM77/87SR25N, DM77SR476BJ, DM77SR25BJ, DM77/87SR476BN or DM77/87SR25BN See NS Package J24F or N24C

Symbol	Parameter	Conditions		'SR476, '7SR25			7SR476 37SR25	,	Units
			Min.	Typ.	Max.	Min.	Typ.	Max.	
I <sub>IL</sub>	Input Load Current	$V_{CC} = Max., V_{IN} = 0.45V$		-80	-250		-80	-250	μΑ
	Innut I calcage Current	$V_{CC} = Max., V_{IN} = 2.7V$			25			25	μΑ
Ιн	Input Leakage Current	$V_{CC} = Max., V_{IN} = 5.5V$	· ·		1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC} = Min., I_{OL} = 16mA$		0.35	0.50		0.35	0.45	٧
V <sub>IL</sub>	Low Level Input Voltage				0.80			0.80	٧
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0			٧
loz	Output Leakage Current	V <sub>CC</sub> = Max., V <sub>CEX</sub> = 2.4V			50			50	μΑ
V <sub>C</sub>	Input Clamp Voltage	$V_{CC} = Min., I_{IN} = -18mA$		-0.8	-1.2		-0.8	-1.2	٧
Cı	Input Capacitance	$V_{CC} = 5.0$ , $V_{IN} = 2.0 V$ $T_A = 25$ °C, 1 MHz		4.0			4.0		pF
Co	Output Capacitance	$V_{CC} = 5.0 \text{ V}, V_O = 2.0 \text{ V}$ $T_A = 25^{\circ}\text{C}, 1 \text{ MHz}, \text{ Outputs Off}$		6.0			6.0		рF
Icc	Power Supply Current	V <sub>CC</sub> = Max., Inputs Grounded All Outputs Open		135	185		135	185	mA
	TRI-STATE Parameters								
los	Short Circuit Output Current	$V_O = 0 V$ , $V_{CC} = Max$ . (Note 4)	-20		-70	-20		-70	mA
loz	Output Leakage (TRI-STATE)	$V_{CC} = Max., V_O = 0.45 \text{ to } 2.4 \text{ V}$ Chip Disabled	-50		+50	-50	-	+50	μА
		I <sub>OH</sub> = -2.0mA	2.4	3.2					٧
$V_{OH}$	Output Voltage High	lou = -6.5mA				2.4	3.2		V

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25^{\circ}C$ . Note 4: During  $I_{OS}$  measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

# **Switching Characteristics**

Symbol	Parameter			SR476, 7SR25,			SR476		Units
,			Min.	Тур.	Max.	Min.	Тур.	Max.	
t <sub>S(A)</sub>	Address to CLK (High) Setup Time	SR476, SR25	55	20		50	20		ns
*S(A)	Address to OER (High) Setup Time	SR476B, SR25B	40	20		35	20 ′		113
t <sub>H(A)</sub>	Address to CLK (High) Hold Time		0	-5		0	-5		ns
t <sub>PHL(CLK)</sub>	Delay from CLK (High) to Output (High or Low)	SR476, SR25 SR476B, SR25B		15 15	30 25		15 15	27 20	ns
twh(CLK)	CLK Width (High or Low)		25	13		25	13		ns
ts(GS)	GS to CLK (High) Setup Time		10 .	0		10	0		ns
t <sub>H(GS)</sub>	GS to CLK (High) Hold Time		5	0		5	0		ns
t <sub>PLH(PS)</sub>	Delay from PS (Low) to Output (High)		20	30		20	25	ns	
t <sub>PLH(ĪNĪT)</sub> t <sub>PHL(ĪNĪT)</sub>	Delay from INIT (Low) to Output (Low	Delay from INIT (Low) to Output (Low or High)			30		20	25	ns
t <sub>WL(PS)</sub>	PS Pulse Width (Low)		15	10		15	10		ns
t <sub>WL(INIT)</sub>	INIT Pulse Width (Low)		15	10		15	10		
t <sub>S(PS)</sub>	PS Recovery (High) to CLK (High)		25	10		20	10		ns
t <sub>S(ĪNĪT)</sub>	INIT Recovery (High) to CLK (High)		25	10		20	10		ns
t <sub>PZL(CLK)</sub> t <sub>PZH(CLK)</sub>	Delay from CLK (High) to Active Outp	ut (High or Low)		20	35		20	30	ns
t <sub>PZL(G)</sub> t <sub>PZH(G)</sub>	Delay from G (Low) to Active Output (Low or High)			15	30		15	25	ns
t <sub>PLZ(CLK)</sub> t <sub>PHZ(CLK)</sub>	Delay from CLK (High) to Inactive Output (TRI-STATE)			20	35		20	30	ns
$t_{PLZ(\overline{G})}$ $t_{PHZ(\overline{G})}$	Delay from $\overline{G}$ (High) to Inactive Outpu	t (TRI-STATE)		15	30		15	25	ns



# DM54/74S572, DM54/74S573; DM54/74S572A, DM54/74S573A; DM54/74S573B (1024 × 4) 4096-Bit TTL PROMs

#### **General Description**

These Schottky memories are organized in the popular 1024 words by 4 bits configuration. Memory enable inputs are provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 4 outputs go to the "OFF" or high impedance state. The memories are available in both open-collector and TRI-STATE® versions.

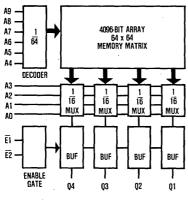
PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

#### **Features**

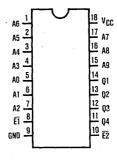
- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access—25ns typ Enable access—15ns typ Enable recovery—15ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming

	Military	Commercial	Open- Collector	TRI-STATE	Package
DM74S572		Х	Х		N,J
DM74S573		Х		X	N,J
DM54S572	Х		X		J
DM54S573	X			Х	j

#### **Block and Connection Diagram**



Order Number; DM74S572 J, DM74S573 J, DM54S572 J, or DM54S573 J See NS Package-J18A



Order Number; DM74S572 N or DM74S573 N See NS Package N18A

0	Downwoodow	DM54S572/573 I		DM	748572	/573	I Imita		
Sym	Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
1 <sub>1L</sub>	Input Load Current	$V_{CC} = Max$ , $V_{IN} = 0.45V$		-80	-250		-80	-250	μΑ
ItH	Input Leakage Current	$V_{CC} = Max$ , $V_{IN} = 2.7V$			25			25	μА
		$V_{CC} = Max$ , $V_{IN} = 5.5V$			1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16mA		0.35	0.50		0.35	0.45	V
VIL	Low Level Input Voltage				0.80			0.80	V
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0			V
loz	Output Leakage Current	$V_{CC} = Max$ , $V_{CEX} = 2.4V$			50			50	μΑ
	(Open-Collector Only)	$V_{CC} = Max, V_{CEX} = 5.5V$			100			100	μΑ
V <sub>C</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18mA		-0.8	-1.2		-0.8	-1.2	V
Cı	Input Capacitance	$V_{CC} = 5.0, V_{IN} = 2.0V$		4.0			4.0		pF
		T <sub>A</sub> = 25C, 1MHz							
Co	Output Capacitance	$V_{CC} = 5.0V$ , $V_O = 2.0V$ $T_A = 25C$ , 1MHz, Outputs Off		6.0			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max, Inputs Grounded All Outputs Open		100	140		100	140	mA

#### TRI-STATE® Parameters

los	Short Circuit Output Current	$V_O = 0V$ , $V_{CC} = Max$ (Note 4)	-20		-70	-20		-70	mA
loz	Output Leakage	$V_{CC} = Max, V_O = 0.45 \text{ to } 2.4V$			+50			+50	μΑ
	(TRI-STATE)	Chip Disabled			-50			-50	μΑ
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = -2.0mA	2.4	3.2					V
		I <sub>OH</sub> = 6.5mA				2.4	3.2		V

#### AC Electrical Characteristics (With Standard Load and Operating Conditions)

Sym	Parameter	JEDEC Symbol	DM	54S572	/573	DM	748572	/573	Units
- Oyiii	raianetei	ULDEO SYMBO	Min	Тур	Max	Min	Тур	Max	·
TAA	Address Access Time	TAVQV		40	75		40	60	ns
TEA	Enable Access Time	TEVQV		20	45		20	35	ns
TER	Enable Recovery Time	TEXQX		20	45		20	35	ns
TZX	Output Enable Time	TEVQX		20	45		20	35	ns
TXZ	Output Disable Time	TEXQZ		20	45		20	35	ns

## AC Electrical Characteristics (With Standard Load and Operating Conditions)

Sym	Danamatan	IEDE	JEDEC Symbol		4S572A/57	3A, B	DM7	3A, B	linian	
Sym	Parameter	JEDE	С Зутьої	Min	Тур	Max	Min	Тур	Max	Units
TAA	Address Access Time	TAVQV	572A/573A		25	60		25	45	ns
			573B		25	50		25	35	ns
TEA	Enable Access Time	TEVQV			15	35		15	25	ns
TER	Enable Recovery Time	TEXQX	,		15	35		15	25	ns
TZX	Output Enable Time	TEVQX			15	35		15	25	ns
TXZ	Output Disable Time	TEXQZ		,	15	35		15	25	ns

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25C$ .

Note 4: During I<sub>OS</sub> measurement, only one output at a time should be grounded. Permanent damage may otherwise result.



DM77/87S180/DM77/87S181; DM77/87S181A; DM77/87S280/DM77/87S281; DM77/87S281A (1024 × 8) 8192-Bit TTL PROMs

#### **General Description**

These Schottky memories are organized in the popular 1024 words by 8 bits configuration. Memory enable inputs are provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 8 outputs go to the "OFF" or high impedance state. The memories are available in both open-collector and TRI-STATE® versions.

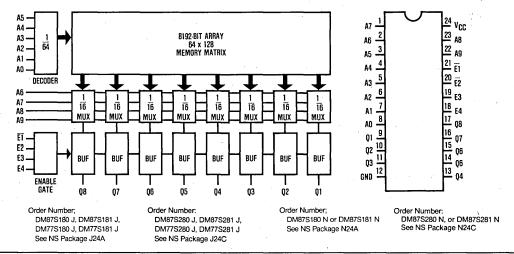
PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

#### **Features**

- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access—35ns typ Enable access—15ns typ Enable recovery—15ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming

	Military	Commercial	Open- Collector	TRI-STATE	Package	24-Pin Standard	24-Pin Narrow-Dip
DM87S180		Х	х		N,J	Х	
DM87S181		X		X	N,J	Х	
DM77S180	Х		Х		J	Х	
DM77S181	Х			Х	J	Х	
DM87S280		X	Х		N,J		X
DM87S281		Х		X	N,J		X
DM77S280	X		Х		J		X
DM77S281	Х			X	J		X

#### **Block and Connection Diagram**



Sym	Parameter	Conditions		77S180 77S280			37S180 37S280		Units
٠,		001141140110	Min	Тур	Max	Min	Тур	Max	
IIL	Input Load Current	$V_{CC} = Max$ , $V_{IN} = 0.45V$		-80	-250		-80	-250	μА
I <sub>IH</sub>	Input Leakage Current	$V_{CC} = Max$ , $V_{IN} = 2.7V$			25			25	μΑ
		$V_{CC} = Max, V_{IN} = 5.5V$			1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16mA		0.35	0.50		0.35	0.45	V
VIL	Low Level Input Voltage			,	0.80			0.80	V
VIH	High Level Input Voltage		2.0			2.0			V
loz	Output Leakage Current	V <sub>CC</sub> = Max, V <sub>CEX</sub> = 2.4V			50			50	μΑ
*	(Open-Collector Only)	V <sub>CC</sub> = Max, V <sub>CEX</sub> = 5.5V			100			100	μА
V <sub>C</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18mA		-0.8	-1.2		-0.8	-1.2	V
Cı	Input Capacitance	$V_{CC} = 5.0, V_{IN} = 2.0V$		4.0			4.0		pF
	4.	$T_A = 25C$ , 1MHz							
Co	Output Capacitance	$V_{CC} = 5.0V$ , $V_O = 2.0V$ $T_A = 25C$ , 1MHz, Outputs Off		6.0			6.0		pF
lcc	Power Supply Current	V <sub>CC</sub> = Max, Inputs Grounded All Outputs Open		115	170		115	170	mA
TRI-	STATE® Parameters								

1										
los	Short Circuit Output Current	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max (Note 4)	-20		-70	-20		-70	mA	
loz	Output Leakage	$V_{CC} = Max, V_{O} = 0.45 \text{ to } 2.4V$			+50			+50	μΑ	
	(TRI-STATE)	Chip Disabled			-50			-50	μΑ	
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = -2.0mA	2.4	3.2					٧	
	6.1	I <sub>OH</sub> = 6.5mA				2.4	3.2		٧	

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

Sym	Parameter	JEDEC Symbol		DM77S180/181 DM87S180/181 DM77S280/281 DM87S280/281				Units	
			Min	Тур	Max	Min	Тур	Max	
TAA	Address Access Time	TAVQV	<del> </del>	40	75		40	55	ns
TEA	Enable Access Time	TEVQV		15	35		15	30	ns
TER	Enable Recovery Time	TEXQX		15	35		15	30	ns
TZX	Output Enable Time	TEVQX	1	15	35		15	30	ns ·
TXZ	Output Disable Time	TEXQZ		15	35	Ĭ .	15	30	ns

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

Cum	Parameter	ICDEC Combal	DM77S181A		D	DM87S181A		Units	
Sym	Parameter	JEDEC Symbol	Min	Тур	Max	Min	Тур	Max	Units
TAA	Address Access Time	TAVQV		35	65		35	45	ns
TEA	Enable Access Time	TEVQV		15	35		15	30	ns
TER	Enable Recovery Time	TEXQX		15	35		15	30	ns
TZX	Output Enable Time	TEVQX		15	35		15	- 30	ns
TXZ	Output Disable Time	TEXQZ		15	35		15	30	ns

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25C$ .

Note 4: During I<sub>OS</sub> measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

# National Semiconductor

# **Bipolar PROMs**

# DM77/87LS181 (1024 X 8) 8192-Bit TTL PROMs

#### **General Description**

These Schottky memories are organized in the popular 1024 words by 8 bits configuration. Memory enable inputs are provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 8 outputs go to the "OFF" or high impedance state. The memories are available in TRI-STATE® versions.

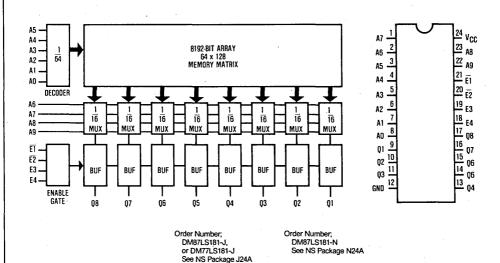
PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

#### **Features**

- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access—100ns typ Enable access—35ns typ Enable recovery—35ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming

	Military	Commercial	Open- Collector	TRI-STATE	Package
DM87LS181		X		· x	N,J
DM77LS181	×			×	J

#### **Block and Connection Diagram**



# 21

DC	Floc	trical	Charac	teristics	(Noto 3)

_		0 111	DM77LS181		181	D	DM87LS181		
Sym	Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
Ι <sub>ΙL</sub>	Input Load Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.45V			-150			-100	μΑ
I <sub>IH</sub>	Input Leakage Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 5.5V			40			50	μΑ
VOL	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 8mA			0.50			0.45	٧
V <sub>IL</sub>	Low Level Input Voltage				0.80			0.80	٧
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0			٧
V <sub>C</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18mA			-1.2			-1.2	V
C <sub>l</sub>	Input Capacitance	$V_{CC} = 5.0$ , $V_{IN} = 2.0V$ $T_A = 25C$ , 1MHz		4.0			4.0		pF
Co	Output Capacitance	$V_{CC} = 5.0V$ , $V_O = 2.0V$ $T_A = 25C$ , 1MHz, Outputs Off		6.0			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max, Inputs Grounded All Outputs Open			100			. 100	mA

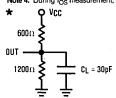
#### TRI-STATE® Parameters

los	Short Circuit Output Current	V <sub>Q</sub> = 0V, V <sub>CC</sub> = Max (Note 4)	-10		-70	-10		-85	mA
loz	Output Leakage	$V_{CC} = Max, V_{O} = 0.5 \text{ to } 5.5V$			+50			+40	μΑ
	(TRI-STATE)	Chip Disabled			-50			-40	μΑ
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = -1.0mA	2.4	3.2					V
		I <sub>OH</sub> = 1.6mA				2.4	3.2		V

## AC Electrical Characteristics (With Specified Load\* and Operating Conditions)

Sum	Da	IFDFO Oh -I	DN	/177LS	181	DI	/187LS1	81	Units
Sym	Parameter	JEDEC Symbol	Min	Тур	Max	Min	Тур	Max	
TAA	Address Access Time	TAVQV			120			100	ns
TEA	Enable Access Time	TEVQV			70			50	ns
TER	Enable Recovery Time	TEXQX			70			50	ns
TZX	Output Enable Time	TEVQX			70			50	ns
TXZ	Output Disable Time	TEXQZ			70			50	ns

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25C$ . Note 4: During  $I_{OS}$  measurement, only one output at a time should be grounded. Permanent damage may otherwise result.



# DM77/87SR181 (1024×8) 8k-Bit Registered TTL PROM

#### **General Description**

The DM77/87SR181 is an electrically programmable Schottky TTL read-only memory with D-type, masterslave registers on chip. This devices is organized as 1024-words by 8-bits and is available in the tri-state output version. Designed to optimize system performance, this device also substantially reduces the cost and size of pipelined microprogrammed systems and other designs wherein accessed PROM data is temporarily stored in a register. The DM77/87SR181 also offers maximal flexibility for memory expansion and data bus control by providing both synchronous and asynchronous output enables. All outputs will go into the "OFF" state if the synchronous chip enable (GS) is high before the rising edge of the clock, or if the asynchronous chip enable (G) is held high. The outputs are enabled when GS is brought low before the rising edge of the clock and G is held low. The GS flip-flop is designed to power up to the "OFF" state with the application of V<sub>CC</sub>.

Data is read from the PROM by first applying an address to inputs A0-A9. During the setup time the output of the array is loaded into the master flip-flop of the data register. During the rising edge (low to high transition) of the clock, the data is then transferred to the slave of the flip-flop and will appear on the output if the output is enabled. Following the rising edge clock transition the addresses and synchronous chip enable can be removed and the output data will remain stable.

TRI-STATE\* is a registered trademark of National Semiconductor Corp. TRI-SAFETM is a trademark of National Semiconductor Corp.

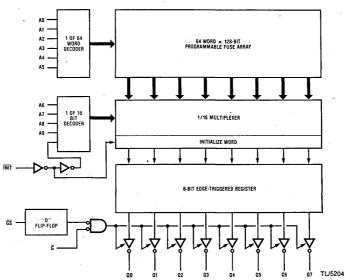
The DM77SR181 also features an initialize function  $\overline{\text{INIT}}$ . The initialize function provides the user with an extra word of programmable memory which is accessed with single pin control by applying a low on  $\overline{\text{INIT}}$ . The initialize function is synchronous and is loaded into the output register on the next rising edge of the clock. The unprogrammed state of the  $\overline{\text{INIT}}$  is all lows.

PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions. Once programmed, it is impossible to go back to a low.

#### **Features**

- On-chip, edge-triggered registers
- Synchronous and asynchronous enables for word expansion
- Programmable register INITIALIZE
- 24-pin, 300 mil package
- 40ns address setup and 20ns clock to output for maximum system speed
- Highly reliable, titanium tungsten fuses
- TRI-STATE® outputs
- Low voltage TRI-SAFETM programming
- All parameters guaranteed over temperature

## **Block Diagram**



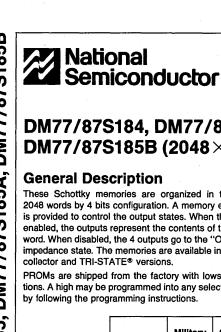
0		0	D	M77SR	181	DI	V187SR1	181	
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Min.	Typ.	Max.	Units
l <sub>IL</sub>	Input Load Current	$V_{CC} = Max., V_{IN} = 0.45V$		-80	-250		-80	-250	μΑ
1	Input Lookage Current	$V_{CC} = Max., V_{IN} = 2.7V$			25			25	μΑ
I <sub>IH</sub>	Input Leakage Current	$V_{CC} = Max., V_{IN} = 5.5V$			1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC} = Min., I_{OL} = 16mA$		0.35	0.50		0.35	0.45	٧
$V_{IL}$	Low Level Input Voltage				0.80			0.80	V
$V_{IH}$	High Level Input Voltage		2.0			2.0			٧
loz	Output Leakage Current	$V_{CC} = Max., V_{CEX} = 2.4 V$			50			50	μΑ
V <sub>C</sub>	Input Clamp Voltage	$V_{CC} = Min., I_{IN} = -18 \text{ mA}$		-0.8	-1.2		-0.8	-1.2	٧
C <sub>I</sub>	Input Capacitance	$V_{CC} = 5.0$ , $V_{IN} = 2.0$ V $T_A = 25$ °C, 1 MHz		4.0			4.0		pF
Co	Output Capacitance	$V_{CC} = 5.0 \text{ V}, V_O = 2.0 \text{ V}$ $T_A = 25^{\circ}\text{C}, 1 \text{ MHz}, \text{ Outputs Off}$		6.0			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max., Inputs Grounded All Outputs Open		115	175		115	175	mA
	TRI-STATE Parameters								
Ios	Short Circuit Output Current	$V_O = 0V$ , $V_{CC} = Max$ . (Note 4)	-20		-70	-20		-70	mA
l <sub>oz</sub>	Output Leakage (TRI-STATE)	$V_{CC} = Max., V_O = 0.45 \text{ to } 2.4V$ Chip Disabled	-50		+50	-50		+50	μА
	0.44.7/-1411/	I <sub>OH</sub> = -2.0mA	2.4	3.2					٧
$V_{OH}$	Output Voltage High	I <sub>OH</sub> = -6.5mA				2.4	3.2		V

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25^{\circ}C$ . Note 4: During  $I_{OS}$  measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

# **Switching Characteristics**

Cumbal	Danamatas	04!4!	DN	/177SR1	81	Di	/187SR1	81	11
Symbol	Parameter   Conditions   Min.   Typ.   Max.   Min.   Typ.	Тур.	Max.	Units					
t <sub>S(A)</sub>	Address to CLK (High) Setup Time		50	20		40	20		ns
t <sub>H(A)</sub>	Address to CLK (High) Hold Time		0	-5		0	-5		ns
t <sub>S</sub> (INIT)	INIT to CLK (High) Setup Time	C <sub>1</sub> = 30 p.F.	35	20		30	20		ns
t <sub>H</sub> (INIT)	INIT to CLK (High) Hold Time	O[ = 00pi	0	-5		0	-5		ns
t <sub>PHL(CLK)</sub>				15	30		15	20	ns
twh(CLK) twt(CLK)	CLK Width (High or Low)		25	13		20	13		ns
t <sub>S(GS)</sub>	GS to CLK (High) Setup Time	•	15	0		15	0		ns
t <sub>H(GS)</sub>	GS to CLK (High) Hold Time		5	0		5	0		ns
t <sub>PZL(CLK)</sub>		,		20	30		20	25	ns
t <sub>PZH(CLK)</sub>	Output (High or Low)	C <sub>L</sub> = 30 n F		20	30		20	25	ns
t <sub>PZL(G)</sub>	, , ,	OL = 00p1		15	30		15	25	ns
t <sub>PZH(G)</sub>	Output (High or Low)			15	30		15	25	ns
t <sub>PLZ(CLK)</sub>				20	30		20	25	ns
t <sub>PHZ(CLK)</sub>	Output (TRI-STATE)	$C_1 = 5pF \text{ (Note 1)}$		20	30		20	25	ns
t <sub>PLZ(G)</sub>	Delay from G (High) to Inactive	or - ob. (Note i)		15	30		15	25	ns
t <sub>PHZ(G)</sub>	Output (TRI-STATE)			15	30		15	25	ns

Note: All typical values are for  $V_{CC} = 5 V$ ,  $T_A = 25 ^{\circ} C$ .



# DM77/87S184, DM77/87S185, DM77/87S185A, DM77/87S185B (2048×4) 8192-Bit TTL PROMs

These Schottky memories are organized in the popular 2048 words by 4 bits configuration. A memory enable input is provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 4 outputs go to the "OFF" or high impedance state. The memories are available in both opencollector and TRI-STATE® versions.

PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

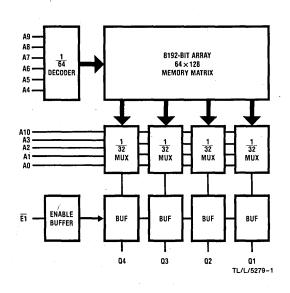
#### **Features**

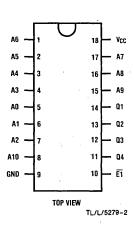
- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access-35 ns max (B Version) Enable access---15 ns typ Enable recovery-15 ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming

	Military	Commercial	Open- Collector	TRI-STATE	Package
DM87S184		Х	X		N,J
DM87S185		Х		X	N,J
DM77S184	х		х		J
DM77S185	Х			Х	J

TBI-STATE® is a registered trademark of National Semiconductor Corn TRI-SAFETM and STARPLEXTM are trademarks of National Semiconductor Corp.

## **Block and Connection Diagram**





Symbol I <sub>IL</sub>	Parameter  Input Load Current	Conditions	Min		77S184/185		DM87S184/185		
	<del></del>	V== = Max V == 0.45V		Тур	Max	Min	Тур	Max -250 25 1.0 0.45 0.80 50 100 -1.2	Units
l <sub>iH</sub>		$V_{CC} = Max, V_{IN} = 0.45V$		-80	-250		-80	-250	μΑ
	Input Leakage Current	$V_{CC} = Max, V_{IN} = 2.7V$			25			25	μΑ
		$V_{CC} = Max, V_{IN} = 5.5V$			1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16 mA		0.35	0.50		0.35	0.45	>
V <sub>IL</sub>	Low Level Input Voltage	(			0.80			0.80	>
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0			>
loz	Output Leakage Current	V <sub>CC</sub> = Max, V <sub>CEX</sub> = 2.4V			50			50	μΑ
	(Open-Collector Only)	V <sub>CC</sub> = Max, V <sub>CEX</sub> = 5.5V			100			100	μΑ
V <sub>C</sub>	Input Clamp Voltage	$V_{CC} = Min, I_{IN} = -18 \text{ mA}$		-0.8	-1.2		-0.8	-1.2	٧
Ci	Input Capacitance	$V_{CC} = 5.0$ , $V_{IN} = 2.0V$ $T_A = 25C$ , 1 MHz		4.0			4.0		pF
Co	Output Capacitance	$V_{CC} = 5.0V$ , $V_O = 2.0V$ $T_A = 25C$ , 1 MHz, Outputs Off		6.0			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max, Input Grounded All Outputs Open		100	140		100	140	mA
RI-STAT	E Parameters								
los	Short Circuit Output Current :	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max (Note 4)	-20		-70	-20		-70	mA
loz	Output Leakage (TRI-STATE)	V <sub>CC</sub> = Max, V <sub>O</sub> = 0.45 to 2.4V Chip Disabled	50		+ 50	-50		+50	μА

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

 $I_{OH} = -2.0 \text{ mA}$ 

 $I_{OH} = -6.5 \, \text{mA}$ 

Output Voltage High

VOH

Symbol	JEDEC Symbol	Parameters	DI	A77S184/	185	DA	DM87S184/185		
· · · · · ·	0252007501		Min	Тур	Max	Min	Тур	Max	Units
TAA	TAVQV	Address Access Time		40	70		40	55	ns
TEA	TEVQV	Enable Access Time		15	30		15	25	ns
TER	TEXQX	Enable Recovery Time		15	30		15	25	ns
TZX	TEVQX	Output Enable Time		15	30		15	25	ns
TXZ	TEXQZ	Output Disable Time		15	30		15	25	ns

2.4

3.2

2.4

3.2

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

Symbol	JEDEC Symbol		Parameters	DM77S185A/B			DI	A/B	Units	
Oybo.	J. J. J. J. J. J. J. J. J. J. J. J. J. J	, y	r arameters	Min	Тур	Max	Min	Тур	Max	Oilles
TAA	TAVQV	185A	Address Access Time		30	60		30	45	ns
		185B			25	50		25	35	ns
TEA	TEVQV		Enable Access Time		15	30		15	25	ns
TER	TEXQX		Enable Recovery Time		15	30		15	25	ns
TZX	TEVQX		Output Enable Time		15	30 .		15	25	ns
TXZ	TEXQZ		Output Disable Time		15	30		15	25	ns

Note 3: These limits apply over the entire operating range unless otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25C$ .

Note 4: During IOS measurement, only one output at a time should be grounded. Permanent damage may otherwise result.



DM77/87S190, DM77/87S191; DM77/87S290, DM77/87S291; DM77/87S190A, DM77/87S191A; DM77/87S290A, DM77/87S291A; DM77/87S190B. DM77/87S191B; DM77/87S290B, DM77/87S291B (2048×8) 16,384-Bit TTL PROMs

#### **General Description**

These Schottky memories are organized in the popular 2048 words by 8 bits configuration. Memory enable inputs are provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 8 outputs go to the "OFF" or high impedance state. The memories are available in both open-collector and TRI-STATE® versions.

PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

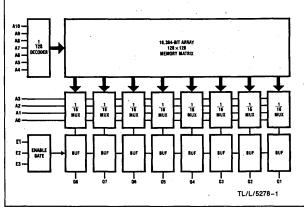
#### **Features**

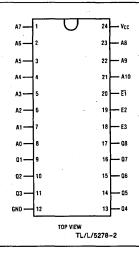
- Advanced tungsten (W) fuses
- Schottky-clamped for high speed Address access-35 ns max (B version) Enable access-15 ns typ Enable recovery-15 ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming

	Military	Commercial	Open- Collector	TRI-STATE	Package	24-Pin Standard	24-Pin Thin-Dip
DM87S190		Х	Х		N,J	X	
DM87S191		Х		Х	N,J	Х	
DM77S190	×		Х		J	×	
DM77S191	×			Х	J	Х	
DM87S290		Х	·x		N,J		Х
DM87S291		Х		Х	N,J		Х
DM77S290	X		Х		J		х
DM77S291	×			Х	J		Х

TRI-STATE® is a registered trademark of National Semiconductor Corporation TRI-SAFETM and STARPI EXTM are trademarks of National Semiconductor Corporation

#### **Block and Connection Diagrams**





#### AC Electrical Characteristics (With Standard Load and Operating Conditions)

JEDEC S	JEDEC Symbol		Parameter	DM77S190/191 DM77S290/291		DI DI	Units			
				Min	Тур	Max	Min	Тур	Max	
TAVQV	191A	t <sub>AA</sub>	Address Access Time		35	60		35	45	ns
	191B				30	30		30	35	ns
TEVQV		tEA	Enable Access Time		15	35		15	30	ns
TEXQX		tER	Enable Recovery Time		15	35		15	30	ns
TEVQX		t <sub>ZX</sub>	Output Enable Time		15	35		15	30	ns
TEXQZ		t <sub>XZ</sub>	Output Disable Time		15	35		15	30	ns

#### DC Electrical Characteristics (Note 3)

Symbols	Parameter	Condition		177S190 177S290		DM DM	Units		
			Min	Тур	Max	Min	Тур	Max	
I <sub>IL</sub>	Input Load Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.45V		-80	-250		-80	-250	μΑ
l <sub>iH</sub>	Input Leakage Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 2.7V			25			25	μΑ
		V <sub>CC</sub> = Max, V <sub>IN</sub> = 5.5V			1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16 mA		0.35	0.50		0.35	0.45	V
V <sub>IL</sub>	Low Level Input Voltage				0.80			0.80	٧
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0`			V
loz	Output Leakage Current	V <sub>CC</sub> = Max, V <sub>CEX</sub> = 2.4V			50			50	μА
	(Open-Collector Only)	V <sub>CC</sub> = Max, V <sub>CEX</sub> = 5.5V			100			100	μΑ
V <sub>C</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18 mA		-0.8	-1.2		-0.8	-1.2 <sup>°</sup>	V
CI	Input Capacitance	V <sub>CC</sub> = 5.0V, V <sub>IN</sub> = 2.0V T <sub>A</sub> = 25°C, 1 MHz		4.0			4.0		pF
Co	Output Capacitance	$V_{CC} = 5.0V$ , $V_{O} = 2.0V$ $T_{A} = 25^{\circ}C$ , 1 MHz, Outputs Off		6.0			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max, Input Grounded All Outputs Open		120	175		, 120	175	mA
TRI-STATE	Parameters					•			
los	Short Circuit Output Current	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max (Note 4)	-20		-70	-20		-70	mA
loz	Output Leakage (TRI-STATE)	V <sub>CC</sub> = Max, V <sub>O</sub> = 0.45V to 2.4V Chip Disabled	-50		50	-50		50	μΑ
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = -2.0 mA	2.4	3.2					V
	. · ·	I <sub>OH</sub> = -6.5 mA				2.4	3.2		V

## AC Electrical Characteristics (With Standard Load and Operating Conditions)

JEDEC Symbol		Sym	Sym Parameter		DM77S191A/B DM77S291A/B			DM87\$191A/B DM87\$291A/B			
				Min	Тур	Max	Min	Тур	Max		
TAVQV	191A/291A	t <sub>AA</sub>	Address Access Time		30	60		30	45	ns	
-	191B/291B				30	50		30	35	ns	
TEVQV		tEA	Enable Access Time		15	35		15	25	ns	
TEXQX	_	t <sub>ER</sub>	Enable Recovery Time		15	35		15	25	ns	
TEVQX		tzx	Output Enable Time		15	35		15	25	ns	
TEXQZ		txz	Output Disable Time		15	35		15	25	ns	

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for V<sub>CC</sub> = 5.0V and T<sub>A</sub> = 25°C.

Note 4: During IOS measurement, only one output at a time should be grounded. Permanent damage may otherwise result.



# Bipolar PROMs PRELIMINARY

# DM77S195A/DM87S195A, DM77S195B/DM87S195B (4096 × 4) 16,384-Bit TTL PROM

#### **General Description**

These Schottky memories are organized in the popular 4096 words by 4 bits configuration. Memory enable inputs are provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 4 outputs go to the OFF or high impedance state. The memories are available in TRI-STATE® version only.

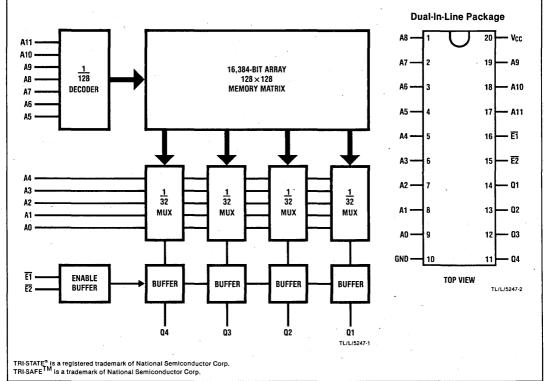
PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

#### **Features**

- Advanced tungsten (W) fuse technology
- Schottky-clamped for high speed Address access—30 ns typ Enable access—15 ns typ Enable recovery—15 ns typ
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE<sup>TM</sup> programming

	Military	Commercial	TRI-STATE	Package
DM87S195A/B		Х	Х	N,J
DM77S195A/B	Х		X	J

# **Block and Connection Diagrams**



Ch - I	D	0	DN	A77S195	A/B	DN	187S195	A/B	Units
Symbol	Parameter	Conditions	Min	Тур	Max	Min	Тур	Max	Units
I <sub>IL</sub>	Input Load Current	$V_{CC} = Max, V_{IN} = 0.45V$		- 80	- 250		- 80	- 250	μΑ
I <sub>IH</sub>	Input Leakage Current	$V_{CC} = Max, V_{IN} = 2.7V$			25			25	μΑ
		$V_{CC} = Max, V_{IN} = 5.5V$			1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16 mA		0.35	0.50		0.35	0.45	٧
V <sub>IL</sub>	Low Level Input Voltage				0.80			0.80	V
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0			V
V <sub>C</sub>	Input Çlamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = - 18 mA		- 0.8	- 1.2		- 0.8	- 1.2	V
Cı	Input Capacitance	$V_{CC} = 5.0V$ , $V_{IN} = 2.0V$ $T_A = 25^{\circ}C$ , 1 MHz		4.0			4.0		pF
Со	Output Capacitance	$V_{CC} = 5.0V$ , $V_O = 2.0V$ $T_A = 25^{\circ}C$ , 1 MHz, Outputs Off		6.0			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max, Inputs Grounded All Outputs Open			170			170	mA
TRI-STA	TE PARAMETERS	,							
Ios	Short Circuit Output Current	$V_O = 0V$ , $V_{CC} = Max$ (Note 4)	- 20		- 70	- 20		- 70	mA
loz	Output Leakage	$V_{CC} = Max, V_{O} = 0.45V \text{ to } 2.4V$			+ 50			+ 50	μА
	(TRI-STATE)	Chip Disabled			- 50			-50	μА
V <sub>OH</sub>	Output Voltage High	I <sub>OH</sub> = - 2.0 mA	2.4	3.2		,			V
	li ia a a li	I <sub>OH</sub> = 6.5 mA		L		2.4	3.2	<u> </u>	V

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25^{\circ}C$ .

Note 4: During IOS measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

# AC Electrical Characteristics (with standard load and operating conditions)

Syn	nbol			DMZ	7S195A	1105B	DMQ	7S195A	/105R	
Alternate	JEDEC Standard	Parameter		Min	Тур	Max	Min	Тур	Max	Units
t <sub>AA</sub>	TAVQV	Address Access Time	195A		30	60		30	45	ns
			195B		30	50		25	35	ns
tEA	TEVQV	Enable Access Time			15	30		15	25	ns
t <sub>ER</sub>	TEXQX	Enable Recovery Time			15	30		15	25	ns
t <sub>ZX</sub>	TEVQX	Output Enable Time			15	30		15	25	ns
t <sub>XZ</sub>	TEXQZ	Output Disable Time			15	30		. 15	25	ns

# Bipolar PROMs PRELIMINARY

# DM77/87S321, DM77/87S421; DM77/87S321A, DM77/87S421A (4096 × 8) 32,768-Bit TTL PROMs

#### **General Description**

These Schottky memories are organized in the popular 4,096 words by 8-bits configuration. Memory enable inputs are provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the eight outputs go to the "OFF" or high impedance state.

PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

The DM77/87S321 and DM77/87S421 program the same as all other nonregistered PROMs from National.

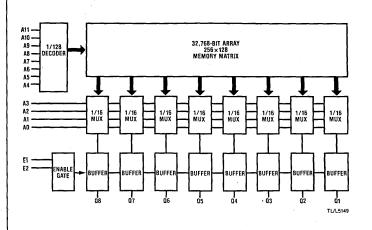
#### **Features**

- Advanced fuse technology
- Schottky-clamped for high speed Address access—35 ns typ.
   Enable access—20ns typ.
   Enable recovery—20ns typ.
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE<sup>TM</sup> programming
- Generic programming.

	Military	Commercial	TRI-STATE®	Package
DM87S321, A		Х	х	N,J
DM77S321, A	Х		Х	J
DM87S421, A		Х	х	N,J*
DM77S421, A	Х		Х	J*

TRI-STATE® is a registered trademark of National Semiconductor Corp. TRI-SAFETM is a trademark of National Semiconductor Corp.

# **Block and Connection Diagrams**





<sup>\*</sup>Thin-Dip (0.3") package

		0	DM	77S321	/421	DM	87S321	/421	
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Min.	Тур.	Max.	Units
I <sub>IL</sub>	Input Load Current	$V_{CC} = Max., V_{IN} = 0.45V$		-80	-250		-80	-250	μΑ
	land back as Course	$V_{CC} = Max., V_{IN} = 2.7V$			25			25	μΑ ,
I <sub>IH</sub>	Input Leakage Current	$V_{CC} = Max., V_{IN} = 5.5 V$			1.0			1.0	mA
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC} = Min., I_{OL} = 12mA$		0.35	0.50		0.35	0.45	٧
V <sub>IL</sub>	Low Level Input Voltage				0.80			0.80	٧
V <sub>IH</sub>	High Level Input Voltage		2.0			2.0	`		٧
V <sub>C</sub>	Input Clamp Voltage	$V_{CC} = Min., I_{IN} = -18 \text{ mA}$		-0.8	-1.2		-0.8	-1.2	٧
Cı	Input Capacitance	$V_{CC} = 5.0$ , $V_{IN} = 2.0$ V $T_A = 25$ °C, 1MHz		4.0			4.0		pF
Со	Output Capacitance	$V_{CC} = 5.0V$ , $V_{O} = 2.0V$ $T_{A} = 25^{\circ}C$ , 1MHz, Outputs Off		6.0			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max., All Outputs Open		135	185		135	185	mA
	TRI-STATE Parameters		•.						
los	Short Circuit Output Current	$V_O = 0 V$ , $V_{CC} = Max$ . (Note 4)	-20		-70	-20		-70	mA
l <sub>oz</sub>	Output Leakage (TRI-STATE)	$V_{CC} = Max., V_O = 0.45 \text{ to } 2.4 \text{ V}$ Chip Disabled	-50		+50	-50		+50	μΑ
		I <sub>OH</sub> = -2.0mA	2.4	3.2					٧
Voн	Output Voltage High	I <sub>OH</sub> = -6.5mA			,	2.4	3.2		V

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

Symbol			DM	DM77S321/421				DM87S321/421		
	Parameter	JEDEC Symbol	Min.	Тур.	Max.	Min.	Тур.	Max.	Units	
T <sub>AA</sub>	Address Access Time	TAVQV		40	65		40	55	ns	
T <sub>EA</sub>	Enable Access Time	TEVQV		20	35		20	30	ns	
T <sub>ER</sub>	Enable Recovery Time	TEXQX		20	35		20	30	ns	
T <sub>ZX</sub>	Output Enable Time	TEVQX		20	35		20	30	ns	
T <sub>XZ</sub>	Output Disable Time	TEXQZ		20	35		20	30	ns	

# AC Electrical Characteristics (With Standard Load and Operating Conditions)

Symbol		15550	DM7	DM77S321A/421A				DM87S321A/421A		
	Parameter	JEDEC Symbol	Min.	Тур.	Max.	Min.	Тур.	Max.	Units	
JAA	Address Access Time	TAVQV		35			35		ns	
T <sub>EA</sub>	Enable Access Time	TEVQV		20		_	20		ns	
T <sub>ER</sub>	Enable Recovery Time	TEXQX		20			20		ns	
T <sub>ZX</sub>	Output Enable Time	TEVQX		20			20		ns	
T <sub>XZ</sub>	Output Disable Time	TEXQZ		20			20		ns	

Note 3: These limits apply over the entire operating range unless stated otherwise. All typical values are for  $V_{CC} = 5.0V$  and  $T_{\Delta} = 25^{\circ}C$ .

Note 4: During IOS measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

#### Non-Registered PROM Programming Procedure

National Schottky PROMs are shipped from the factory with all fuses intact. As a result, the outputs will be low (logical "0") for all addresses. To generate high (logical "1") levels at the outputs, the device must be programmed. Information regarding commercially available programming equipment may be obtained from National. If it is desired to build your own programmer, the following conditions must be observed:

- 1. Programming should be attempted only at ambient temperatures between 15 and 30 degrees Celsius.
- 2. Address and enable inputs must be driven with TTL logic levels during programming and verification.
- 3. Programming will occur at the selected address when V<sub>CC</sub> is at 10.5 volts, and at the selected bit location when the output pin, representing that bit, is at 10.5 volts, and the device is subsequently enabled. To achieve these conditions in the appropriate sequence, the following procedure must be followed:
  - a) Select the desired word by applying high or low levels to the appropriate address inputs. Disable the device by applying a high level to one or more "active low" chip enable inputs.
  - b) Increase  $V_{CC}$  from nominal to 10.5 volts (plus or minus 0.5V) with a slew rate between 1.0 and 10.0V/ $\mu$ s. Since  $V_{CC}$  is the source of the current required to program the fuse as well as the  $I_{CC}$  for the device at the programming voltage, it must be capable of supplying 750mA at 11.0 volts.
  - c) Select the output where a logical high is desired by raising that output voltage to 10.5 volts (plus or minus 0.5V). Limit the slew rate from 1.0 to  $10.0V/\mu s$ . This voltage change may occur simultaneously with the increase in  $V_{CC}$ , but must not precede it. It is critical that only one output at a time be programmed since the internal circuits can only supply programming current to one bit at a time. Outputs not being programmed must be left open or connected to a high impedance source of  $20k\Omega$  minimum (Remember that the outputs of the device are disabled at this time).
  - d) Enable the device by taking the chip enable(s) to a low level. This is done with a pulse of 10μs. The 10μs duration refers to the time that the circuit (device) is enabled. Normal input levels are used and rise and fall times are not critical.
  - e) Verify that the bit has been programmed by first removing the programming voltage from the output and then reducing V<sub>CC</sub> to 4.0 volts (plus or minus 0.2V). Verification at a V<sub>CC</sub> level of 4.0 volts will guarantee proper output states over the V<sub>CC</sub> and temperature range of the programmed part. The device must be enabled to sense the state of the outputs. During verification, the loading of the output must be within specified I<sub>OL</sub> and I<sub>OH</sub> limits. Steps b, c, and d must be repeated up to 10 times or until verification that the bit has been programmed.
  - f) Following verification, apply five additional programming pulses to the bit being programmed. The programming procedure is now complete for the selected bit.
  - g) Repeat steps a through f for each bit to be programmed to a high level. If the procedure is performed on an automatic programmer, the duty cycle of V<sub>CC</sub> at the programming voltage must be limited to a maximum of 25%. This is necessary to minimize device junction temperatures. After all selected bits are programmed, the entire contents of the memory should be verified.

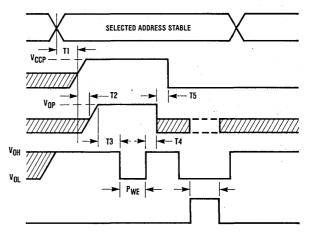
Note: Since only an enabled device is programmed, it is possible to program these parts at the board level if all programming parameters are complied with.

Sym	Parameters	Conditions	Min	Recommended Value	Max	Units
$V_{CCP}$	Required V <sub>CC</sub> for Programming		10.0	10.5	11.0	V
ICCP	I <sub>CC</sub> During Programming	V <sub>CC</sub> = 11V			750	mA
V <sub>OP</sub>	Required Output Voltage for Programming		10.0	10.5	11.0	٧
l <sub>OP</sub>	Output Current while Programming	V <sub>OUT</sub> = 11V			20	mA
I <sub>RR</sub>	Rate of Voltage Change of		1.0		10.0	V/μs
	V <sub>CC</sub> or Output					
P <sub>WE</sub>	Programming Pulse Width (Enabled)		9	10	11	μS
V <sub>CCV</sub>	Required V <sub>CC</sub> for Verification		3.8	4.0	4.2	V
M <sub>DC</sub>	Maximum Duty Cycle for V <sub>CC</sub> at V <sub>CCP</sub>			25	25	%

# Programming Waveforms Non-Registered PROM

 $\begin{array}{l} T1=100 \text{ns min.} \\ T2=5 \mu \text{s min.} T2 \text{ may be}>0 \\ \text{if } V_{CCP} \text{ rises at} \\ \text{the same rate or faster} \\ \text{than } (V_{OP}) \\ T3=100 \text{ns min.} \\ T4=100 \text{ns min.} \\ T5=100 \text{ns min.} \end{array}$ 

P<sub>WE</sub> is repeated for 5 additional pulses after verification of V<sub>OH</sub> indicates a bit has been programmed.



# Registered PROM Programming Procedure

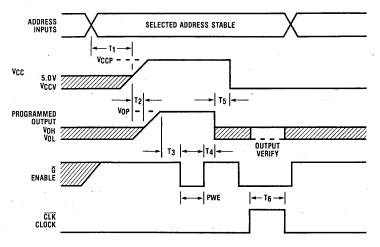
National Schottky PROMs are shipped from the factory with all fuses intact. As a result, the outputs will be low (logical '0') for all addresses. To generate high (logical '1') levels at the outputs, the device must be programmed. Information regarding commercially available programing equipment may be obtained from National. If it is desired to build your own programmer, the following conditions must be observed.

- 1. Programming should be attempted only at ambient temperatures between 15°C and 30°C.
- Address and Enable inputs must be driven with TTL logic levels during programming and verification.
- Programming will occur at the selected address when V<sub>CC</sub> is at 10.5V, and at the selected bit location when the output pin, representing that bit, is at 10.5V, and the device is subsequently enabled. To achieve these conditions in the appropriate sequence, the following procedure must be followed:
  - a) Select the desired word by applying high or low levels to the appropriate address inputs. Disable the device by applying a high level to asynchronous chip Enable input G. GS is held low during the entire programming time.
  - b) Increase  $V_{CC}$  from nominal to 10.5V (±0.5V) with a slew rate between 1.0 and  $10V/\mu s$ . Since  $V_{CC}$  is the source of the current required to program the fuse as well as the  $I_{CC}$  for the device at the programming voltage, it must be capable of supplying 750mA at 11V.
  - c) Select the output where a logical high is desired by raising that output voltage to  $10.5 \text{V} (\pm 0.5 \text{V})$ . Limit the slew rate from 1.0 to  $10 \text{V}/\mu \text{s}$ . This voltage change may occur simultaneously with the increase in  $V_{\text{CC}}$ , but must not precede it. It is critical that only one output at a time be programmed since the internal circuits can only supply programming current to one bit at a time. Outputs not being programmed must be left open or connected to a high impedance source of  $20 \text{k}\Omega$  minimum. (Remember that the outputs of the device are disabled at this time.)

- d) Enable the device by taking the chip enable (G) to a low level. This is done with a pulse of 10μs. The 10μs duration refers to the time that the circuit (device) is enabled. Normal input levels are used and rise and fall times are not critical.
- e) Verify that the bit has been programmed by first removing the programming voltage from the output and then reducing  $V_{\rm CC}$  to 4.0V (± 0.2V). Verification at a  $V_{\rm CC}$  level of 4.0V will guarantee proper output states over the  $V_{\rm CC}$  and temperature range of the programmed part. Each data verification must be preceded by a positive going (low to high) clock edge to load the data from the array into the output register. The device must be enabled to sense the state of the outputs. During verification, the loading of the output must be within specified  $I_{\rm OL}$  and  $I_{\rm OH}$  limits. Steps b, c, and d must be repeated up to 10 times or until verification that the bit has been programmed.
- f) The initialize word is programmed by setting NIT input to a logic low and programming the initialize word output by output in the same manner as any other address. This can be accomplished by inverting the A9 address input from the PROM programmer and applying it to the NIT input. Using this method, the initialize word will program at address 512.
- g) Following verification, apply five additional programming pulses to the bit being programmed. The programming procedure is now complete for the selected bit.
- h) Repeat steps a through f for each bit to be programmed to a high level. If the procedure is performed on an automatic programmer, the duty cycle of V<sub>CC</sub> at the programming voltage must be limited to a maximum of 25%. This is necessary to minimize device junction temperatures. After all selected bits are programmed, the entire contents of the memory should be verified.

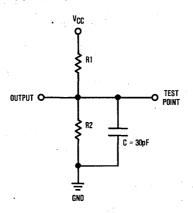
Sym	Parameters	Conditions	Min	Recommended Value	Max	Units
$V_{CCP}$	Required V <sub>CC</sub> for Programming		10.0	10.5	11.0	٧
ICCP	I <sub>CC</sub> During Programming	V <sub>CC</sub> = 11V			750	mA
V <sub>OP</sub>	Required Output Voltage for Programming		10.0	10.5	11.0	٧
l <sub>OP</sub>	Output Current while Programming	V <sub>OUT</sub> = 11V			20	mA
I <sub>RR</sub>	Rate of Voltage Change of		1.0		10.0	V/μs
	V <sub>CC</sub> or Output					
P <sub>WE</sub>	Programming Pulse Width (Enabled)		9	10	11	μS
V <sub>CCV</sub>	Required V <sub>CC</sub> for Verification		3.8	4.0	4.2	V
M <sub>DC</sub>	Maximum Duty Cycle for V <sub>CC</sub> at V <sub>CCP</sub>			25	25	% .

# Programming Waveforms Registered PROM



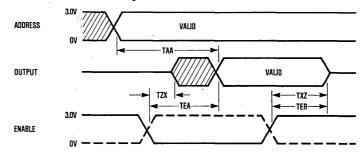
 $T_1=100\,ns$  Min. (  $T_2$  May be >0 if v<sub>CCP</sub> rises at the same rate or faster than v<sub>OP</sub>.)  $T_2=5\mu s$  Min. (  $T_2$  may be >0 if v<sub>CCP</sub> rises at the same rate or faster than v<sub>OP</sub>.)  $T_4=100\,ns$  Min.  $T_6=100\,ns$  Min.  $T_6=50\,ns$  Min.

#### Standard Test Load

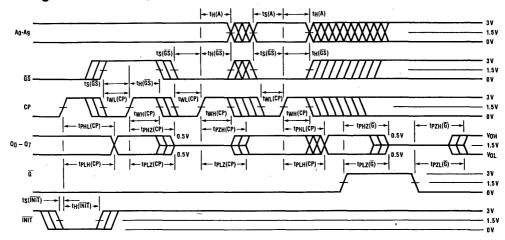


- \* Device input waveform characteristics are; Repetition rate = 1MHz Source impedance = 50Ω Rise and Fall times = 2.5ns max. (1.0 to 2.0 volt levels)
- \* TAA is measured with stable enable inputs.
- TEA and TER are measured from the 1.5 volt level on inputs and outputs with all address and enable inputs stable at applicable levels.
- \* For I $_{OL}$  = 16mA, R1 = 300 $\Omega$  and R2 = 600 $\Omega$  for I $_{OL}$  = 12mA, R1 = 400 $\Omega$  and R2 = 800 $\Omega$ .
- " "C" includes scope and jig capacitance.

## Switching Time Waveforms Non-Registered PROM



#### Switching Waveforms Registered PROM



# **Key To Timing Diagram**

WAVEFORM	INPUTS	OUTPUTS	WAVEFORM	INPUTS	OUTPUTS
	MUST BE Steady	WILL BE STEADY	$\bigcirc$	DON'T CARE: ANY CHANGE PERMITTED	CHANGING: STATE UNKNOWN
	MAY CHANGE From H to L	WILL BE Changing From H to L		DOES NOT APPLY	CENTER LINE IS HIGH IMPEDANCE
	MAY CHANGE FROM L TO H	WILL BE Changing From L to H			"OFF" STATE

# **Approved Programmers for NSC PROMs**

MANUFACTURER

SYSTEM#

DATA I/O PRO-LOG KONTRON STAG 5/17/19/29A M910, M980 MPP80S PPX

AIM DIGELEC STARPLEX<sup>TM</sup> RP400 UP803

# **Quality Enhancement Programs For Bipolar Memory**

	A+ PROGRAM	<b>/</b> 1*	B+ PROGRAM				
Test	Condition	Guaranteed LOT AQL 5	Test	Condition	Guaranteed LOT AQL 5		
	25° C	0.05		25°C	0.05		
D.C. Parametric And Functionality	Each Temperature Extreme	0.05	D.C. Parametric And Functionality	Each Temperature Extreme	0.05		
A.C. Parametric	25°C	0.4	A.C. Parametric`	25°C	0.4		
	Critical	0.01		Critical	0.01		
Mechanical	Major	0.28	Mechanical	Major	0.28		
Seal Tests	rests (5 x 10 -8) Tests		Fine Leak (5 x 10 -8)	0.4			
Hermetic I	Gross	0.4	Hermetic	Gross	0.4		

<sup>\*</sup>Includes 160 hours of burn-in at 125°C.

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# **Bipolar PROMs**

# DM76S64/DM86S64 Bipolar Character Generator

### **General Description**

The DM76S64/DM86S64 is a 64-character bipolar character generator with serial output designed primarily for the CRT display marketplace, and packaged in a standard 16-pin DIP. The DM76S64/DM86S64 incorporates several CRT system level functions, as well as a 7  $\times$  9 or 5  $\times$  7 row scan character font. The DM76S64/DM86S64 performs the system functions of parallel to serial shifting, character address latching, character spacing and character line spacing. These system functions have required extra packages in the past.

Shifted characters can be generated by the on-chip subtractor.

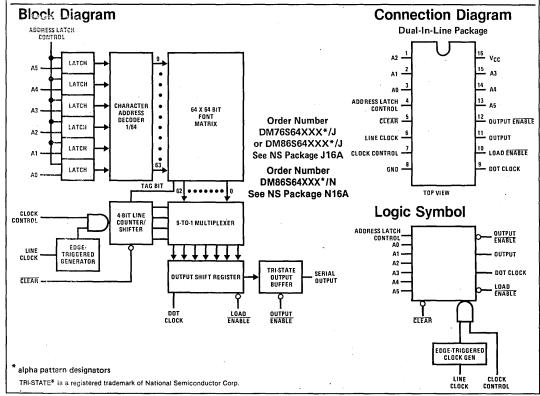
The clear input and the load enable input are active low. Load enable is synchronous with the dot clock. Both the line clock and the dot clock are positive edge-triggered. When the address latch control signal is high.

the character addresses "fall through" the latch. And when the address latch control signal goes low, the character addresses are latched.

### **Features**

- 64-character-row scan
- 5 x 7 or 7 x 9 font
- Custom fonts available with shift options
- Serial output
- 16-pin package
- 35 MHz typ clock rate
- On-chip input latches
- On-chip shift register
- On-chip dot blanking
- On-chip row blanking
- TRI-STATE® output

and the second second	7 x 9	5 x 7	FONT	PACKAGE
DM76S64BWF/DM86S64BWF	X		Upper Case Block Letters	N, J
DM76S64CAE/DM86S64CAE	X		Shifted Lower Case Block	N, J
DM76S64CAB/DM86S64CAB		X	Upper Case Block Letters	N, J
DM76S64CAH/DM86S64CAH	1	X	Shifted Lower Case Block	N, J
DM76S64CTA/DM86S64CTA	X		ASCII Character Set	N, J
DM76S64CTB/DM86S64CTB	×		ASCII Numerals and Control	N, J



Absolute Maximum Rati	Operating Conditions					
			MIN	MAX	UNITS	
Supply Voltage	−0.5V to +7V	Supply Voltage (VCC)				
Input Voltage	-1.5V to +5.5V	DM76S64	4.5	5.5	V	
Output Voltage	-0.5V to +5.5V	DM86S64	4.75	5.25	V	
Storage Temperature Lead Temperature (Soldering, 10 seconds)	–65°C to +150°C 300°C	Ambient Temperature (T <sub>A</sub> ) DM76S64 DM86S64	55 0	+125 +70	°C °C	
		Logical "0" Voltage	0	8.0	V	
		Logical "1" Voltage	2.0	5.5	V	

# DC Electrical Characteristics (Note 2)

SYM	PARAMETER	CONDITIONS		MIN	TYP	MAX	UNITS
ИL	Input Load Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.45V				-800	μΑ .
Чн	Input Leakage Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 2.4V				40	μΑ
t <sub>1</sub>	Input Leakage Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 5.5V	i			1	mA
$v_{OL}$	Low Level Output Voltage	V <sub>CC</sub> = Min, I <sub>OL</sub> = 16 mA	l		0.35	0.45	V
VIL	Low Level Input Voltage	V <sub>CC</sub> = Min				0.80	V
VIH	High Level Input Voltage	V <sub>CC</sub> = Min		2.0			V
٧c	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -12 mA	}		0.8	-1.5	<b>v</b>
CIN	Input Capacitance	V <sub>CC</sub> = 5V, V <sub>IN</sub> = 2V, T <sub>A</sub> = 25°C, 1 MHz			4.0	1	pF
co	Output Capacitance	$V_{CC} = 5V$ , $V_{O} = 2V$ , $T_{A} = 25^{\circ}C$ , 1 MHz, Output "OFF"			6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max, All Inputs Grounded, Output Open			80	140	mA
TRI-STA	TE PARAMETERS						
¹sc	Output Short-Circuit Current	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max		-15		-70	mA
lнz	Output Leakage	$V_{CC}$ = Max, $V_{O}$ = 0.45 to 2.4V, Chip Disabled				±40	μΑ
Voн	Output Voltage High	I <sub>OH</sub> = −2 mA	۶	2.4	3.2		V

# **AC Electrical Characteristics** (Note 2)

				DM76S64			DM86S64		448470
SYM	PARAMETER	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
	Access Time								
$T_{DO}$	Dot Clock to Output			25	50		25	40	ns
TEA	Output Enable	1		10	35		10	30	ns
TER	Output Disable	1 1		13	35		13	30	ns
	Set-Up Time			1				İ	
T <sub>S1</sub>	Load to Dot Clock		25	7		20	7		ns
T <sub>S2</sub>	Address to Load	See	335	54		280	54		ns
T <sub>S3</sub>	Clear to Load	Switching	335	14		280	14		ns
T <sub>S4</sub>	Control to Line Clock	Time	50	-10		40	_10		ns
T <sub>S5</sub>	Line Clock to Load	Waveforms	1140	156		950	156	1	ns
T <sub>S6</sub>	Address to Address Latch		50	6		40	6		· ns
	Hold Time	†							
TH1	Load from Dot Clock		5	-6		0	6	İ	ns
T <sub>H2</sub>	Address from Load		0	<b>–14</b> ⋅		0	_14		ns
T <sub>H3</sub>	Control from Line Clock		120	23		100	23		ns
T <sub>H4</sub>	Address from Address Latch		50	3		40	3		ns

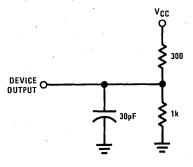
### AC Electrical Characteristics (Continued) (Note 2)

0)/44	242445752	CONDITIONS		DM76S64		DM86S64			
SYM	PARAMETER		MIN	TYP	MAX	MIN	ТҮР	MAX	UNITS
	Pulse Width					1			
T <sub>W1</sub>	Line Clock	·	50	12		40	12		ns
Tw2	Clear		50	6		40	6		ns
TW3	Dot Clock		25	12		20	12		ns
$T_{W4}$	Load		40	8		30	8		ns
$T_{W5}$	Address Latch		50	22		. 40	22		ns
fMAX	Clock Frequency		18	35		22	35	·	MHz

Note 1: Absolute maximum ratings are those values beyond which the device may be permanently damaged. They do not mean that the device may be operated at these values.

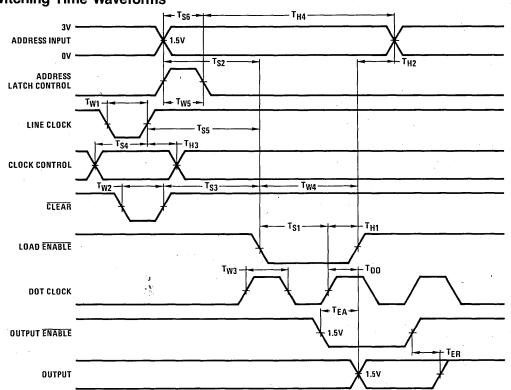
Note 2: These limits apply over the entire operating range unless stated otherwise. All typical values are for V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C.

### Standard Test Load



- Input waveforms are supplied by a pulse generator having the following characteristics: PRR = 1 MHz,  $Z_{OUT}$  = 50  $\Omega$ ,  $t_r < 5$  ns and  $t_f < 5$  ns (between 1.0V and 2.0V).
- TDO is measured with output enable at a steady low level.

# **Switching Time Waveforms**



### **Truth Tables**

#### A) ADDRESS LATCH

ADDRESS LATCH CONTROL	FUNCTION PERFORMED
0	Latched
11	Fall Through

#### B) OUTPUT

OUTPUT ENABLE	STATE OF THE OUTPUT
1	Output Hi-Z
0	Data Out

#### C) 4-BIT LINE COUNTER

CLOCK CONTROL	LINE CLOCK	CLEAR	LINE COUNTER
Н		Н	Increment line counter
X	l x	L	Asynchronous clear
•	ì	Ì	resets counter
L .	X	н	Clock inhibited
Н	¬_	Н	No change on high-to-
			low clock edge

X = Don't care

### **Definitions**

A0-A5: Character address. A 6-bit code which selects 1 of the 64 characters in the font.

Clear: Active low clear for mod 16 row counter, (can be used to truncate mod 16 counter).

Line Clock: Clock that advances the line counter. Advances counter on the low-to-high transition.

Clock Control: Enables line clock when high and disables line clock when low.

Load Enable: Active low load command which routes data from the character ROM to the "D" inputs of the 7-bit shift register.

Dot Clock: A low-to-high transition of the dot clock loads the shift register if load enable is low or shifts data if load enable is high.

Output Enable: An active low output enable. When high the output is in the Hi-Z state.

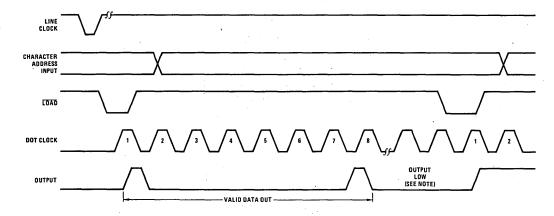
Output: A TTL TRI-STATE output buffer.

# **Functional Description**

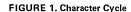
To select a character, a 6-bit binary word must be present at the address inputs A0—A5 when the address latch control is high. This address can be latched by bringing the address latch control signal low after a 40 ns set-up time. When the clear input receives a low pulse, the counter is reset to zero. The shift register can be loaded (Ts2 ns) after the character is addressed. Data, representing 1 horizontal line of the addressed character, is available at the output when the load enable input is brought low. As shown in Figure 1, valid data arrives serially at the output. Dot clock pulses beyond that required to shift out 1 line of the

character will add lows to the end of character. This provides a horizontal spacing between characters.

Figure 2 shows how the counter sequences through the rows of addressed lines with the application of clock pulses at the line clock input. Any additional line clocks beyond that required to display the character will put a vertical space between characters. This spacing can be truncated by bringing the clear input low. Detailed system application infomation is contained in application note AN-167 available from National.



Note. Output goes and stays low following the leading edge of the eighth Dot-Clock pulse until Load enable is enabled again and new parallel data is loaded into the shift register.



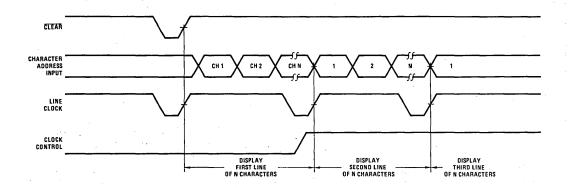


FIGURE 2. Line Cycle

A two character display example is shown in *Figure 3* and a typical system timing waveform is shown in *Figure 4*.

A chip select input is provided for expansion of the character font. The various standard fonts are shown in Figures 5, 6, 7, 8, 9 and 10. Descending characters in the 5 x 7 fonts are shifted by virtue of their placement in the matrix. Descending characters in the 7 x 9 fonts are shifted (by the on-chip line shifter/counter) the number of lines indicated by the number in the upper left hand corner of the character drawings in the figures.

Character Cycle — ROM data corresponding to 1 line of characters is loaded into the shift register TS2 after the ROM is addressed. When load enable goes low, ROM data is allowed to be present at the D input of

the shift register via the MUX. The first bit of the ROM data is transferred to the output at the next low-to-high transition of the dot clock. After load enable goes back high, the second to seventh clock pulses shift out the rest of the selected row of the addressed character. Additional clock pulses will shift out low data used for spacing.

Line Cycle — The line counter is a mod 16 counter. A low-to-high transition of the line clock advances the line counter to the next count. If, for any reason, the counts need to be truncated, a low signal at the clear input resets the counter to zero. The clock control may be used as a line clock disable. A high signal at the line clock control terminal enables the counter and a low signal disables the line clock.

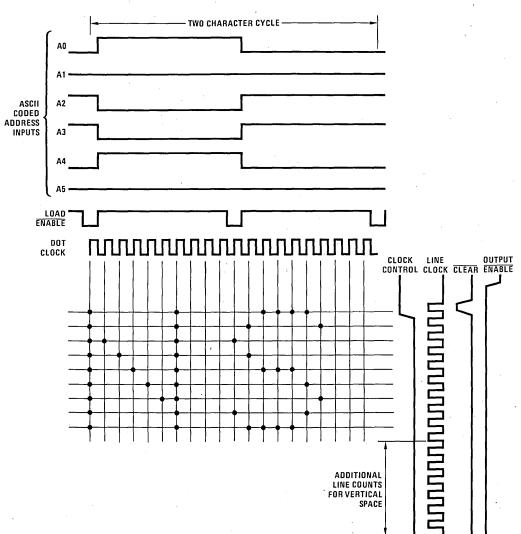
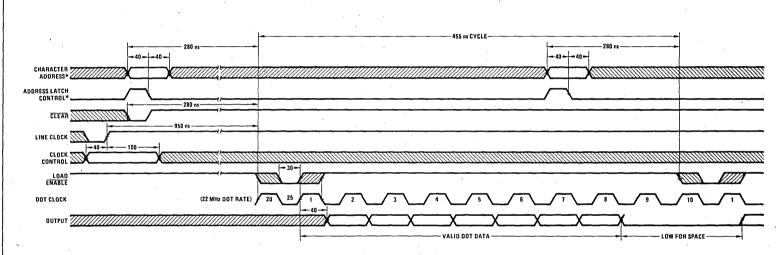


FIGURE 3. Example of Two Characters Display Timing



\*Shown here for operation with dynamic memory. For static memory operation the address latch control would be tied high and the character addresses would be stable between each address change occurring 280 ns before the high-to-low transition of Load enable.

FIGURE 4. Typical System Timing Waveform

A0-A3 A4-A6	0	-	2	В		A4-A6	0	·	2	e	·
						-				4 ************************************	
-						_					!
2						2					
8						m					
4						4					
ın			0.00000000		FIGURE	in .				5550000000	FIGURE
<b>6</b>					5. DM7	9					6.
			000000000 000000000 ##000000 000#00000 000#00000		6S64BWF/	7			4 0 1 1 1 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0		Ç
œ					6864	<b>&amp;</b>					E/DM86S64
G)	000000000				BWF	6				00000000	64CAE
4					† 	A			4 000000000 000000000 000000000 00000000	000000000	
<b>.</b>						m.					
ပ						ပ					
٥						o o					
ш						ш					
u.						u.					

A4-A6 0 1 2 3 4					A4-A6 0 1 2 3 4					
ın .				FIGURE 7. I	un					FIGURE 8. I
2				DM76S64CAB/D	9					DM76S64CAH/DM86S
<b>6</b> 0				M86S64CAB	en en					64CA
٩					٨					
ъ ш					ъ т					
a		000 00000 0000 0000 0000 0000 0000 0000 0000 0000 0000 0000 0000 0000 0000 0000			٥					
· w					ш					
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0			000000000 00000000 00000000 000000000 0000	4
A0-A3	0	-	2	m

FIGURE 9. DM76S64CTA/DM86S64CTA

<del></del>	000000nel	0000=00=0	0=0000000	0
ш				
ш				
0				
ပ			4 000000000000000000000000000000000000	
ω .				40000000000000000000000000000000000000
A				
6				
8				
7				
9				
5				
4				
3				
2				
1				
0				
A0-A3	. 0	-	2	E

FIGURE 10. DM76S64CTB/DM86S64CTB



# DM76S128/DM86S128 Bipolar Character Generator

# **General Description**

The DM76S128/DM86S128 is a 128-character bipolar character generator with serial output designed primarily for the CRT display marketplace, and packaged in a standard 16-pin DIP. The DM76S128/DM86S128 incorporates several CRT system level functions, as well as a 7 x 9 or 5 x 7 row scan character font. The DM76S128/DM86S128 performs the system functions of parallel to serial shifting, character address latching, character spacing and character line spacing. These system functions have required extra packages in the

Shifted characters can be generated by the on-chip adder/subtracter.

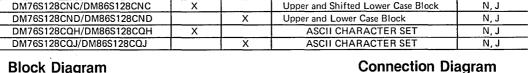
The clear input and the load enable input are active low. Load enable is synchronous with the dot clock. Both the line clock and the dot clock are positive edgetriggered. When the address latch control signal is high, the character addresses "fall through" the latch, And when the address latch control signal goes low, the character addresses are latched.

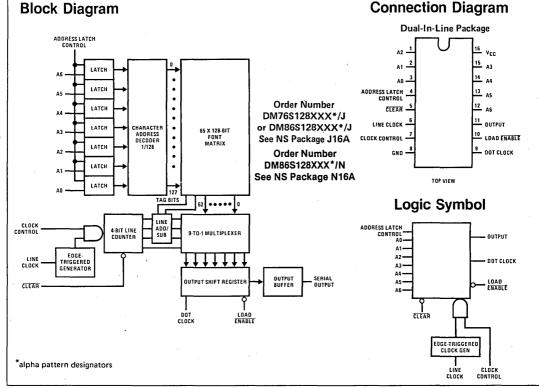
**Bipolar PROMs** 

### **Features**

- 128 character-row scan
- 5 x 7 or 7 x 9 font
- Custom fonts available with shift options
- Serial output
- 16-pin package
- 35 MHz typical clock rate
- On-chip input latches
- On-chip shift register
- On-chip dot blanking
- On-chip row blanking
- Low power—400 mW typical

	7 x 9	5 x 7	FONT	PACKAGE
DM76S128CNC/DM86S128CNC	X		Upper and Shifted Lower Case Block	N, J
DM76S128CND/DM86S128CND		X	Upper and Lower Case Block	N, J
DM76S128CQH/DM86S128CQH	X		ASCII CHARACTER SET	N, J
DM76S128CQJ/DM86S128CQJ		X	ASCII CHARACTER SET	N, J





# Absolute Maximum Ratings (Note 1)

# **Operating Conditions**

			MIN	MAX	UNITS
Supply Voltage Input Voltage Output Voltage	-0.5V to +7V -1.5V to +5.5V -0.5V to +5.5V	Supply Voltage (V <sub>CC</sub> ) DM76S128 DM86S128	4.5 4.75	5.5 5.25	V V
Storage Temperature Lead Temperature (Soldering, 10 seconds)	−65° C to +150° C 300° C	Ambient Temperature (T <sub>A</sub> ) DM76S128 DM86S128	-55 0	+125 +70	°c °c
		Logical "0" Input Voltage (Low)	0	8.0	V
		Logical "1" Input Voltage (High)	2.0	E E	v

# DC Electrical Characteristics (Note 2)

SYM	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
IIL	Input Load Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.45V			-800	μΑ
HH	Input Leakage Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 2.4V			40	μΑ
, II	Input Leakage Current	V <sub>CC</sub> = Max, V <sub>IN</sub> = 5.5V	1.0		1	mA
VOL.	Low Level Output Voltage	VCC = Min, IOL = 16 mA		0.35	0.45	v
Vон	Output Voltage High	I <sub>OH</sub> = −2 mA	2.4	3.2		v
VIL	Low Level Input Voltage	V <sub>CC</sub> = Min			0.80	·V
VIH	High Level Input Voltage	V <sub>CC</sub> = Min	2.0			V
·Vc	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -12 mA		-0.8	-1.5	V
C <sub>IN</sub>	Input Capacitance	$V_{CC} = 5V, V_{IN} = 2V, T_A = 25^{\circ}C,$ 1 MHz		4.0		pF
.c <sub>0</sub> -	Output Capacitance	$V_{CC} = 5V, V_{O} = 2V, T_{A} = 25^{\circ}C,$ 1 MHz		6.0		pF
Icc	Power Supply Current	V <sub>CC</sub> = Max, All Inputs Grounded, Output Open		100	140	mA
Isc	Output Short-Circuit Current	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max	-15	]	_70 ·	mA

# **AC Electrical Characteristics**

DM76S128:  $T_A = -55^{\circ}C$  to +125°C,  $V_{CC} = 4.5V$  to 5.5V.  $C_L = 50$  pF. DM86S128:  $T_A = 0^{\circ}C$  to +70°C,  $V_{CC} = 4.75V$  to 5.25V.  $C_L = 50$  pF.

CVA	DADAMETED		DM76S128		DM86S128			LINUTO
SYM	PARAMETER	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
	Access Time							
TDO	Dot Clock to Output		25	50		25	40	ns
	Set Up Time	`		1				
T <sub>S1</sub>	Load to Dot Clock	25	7 .		20	7		ns
T <sub>S2</sub>	Address to Load	335	54		280	54		ns
T <sub>S3</sub>	Clear to Load	335	14		280	14		ns
T <sub>S4</sub>	Control to Line Clock	50	-10		40	-10		ns
T <sub>S5</sub>	Line Clock to Load	1140	156	1	950	156		ns
T <sub>S6</sub>	Address to Address Latch	50	6	i ·	40	6		ns
	Hold Time				1			
TH1	Load from Dot Clock	5	-6		0	<b>-6</b>		ns
T <sub>H2</sub>	Address from Load	0	14		0	-14		ns.
T <sub>H3</sub>	Control from Line Clock	120	23		100	23		ns
T <sub>H4</sub>	Address from Address Latch	50	3		40	3		ns

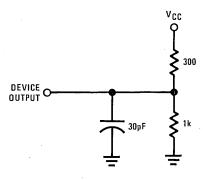
### AC Electrical Characteristics (Continued) (With standard load) (Note 2)

0.44	SAGAMETES.	DM76S128			DM86S128			UNITS
SYM	PARAMETER	MIN	TYP	MAX	MIN	TYP	MAX	OWITS
TW1	Line Clock	50	12		40	12		ns
$T_{W2}$	Clear	50	-6		40	6		ns
$T_{W3}$	Dot Clock	25	12	Ì	20	12		ns
$T_{W4}$	Load	40	8	1	30	8		ns
$T_{W5}$	Address Latch	50	22		40	22		ns
fMAX	Clock Frequency	18	35		22	35		MHz

Note 1: Absolute maximum ratings are those values beyond which the device may be permanently damaged. They do not mean that the device may be operated at these values.

Note 2: These limits apply over the entire operating range unless stated otherwise. All typical values are for V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C.

### Standard Test Load



Input waveforms are supplied by a pulse generator having the following characteristics: PRR = 1 MHz,  $Z_{OUT}$  = 50  $\Omega$ ,  $t_r$  < 5 ns and  $t_f$  < 5 ns (between 1.0V and 2.0V).

### **Truth Tables**

#### A) ADDRESS LATCH

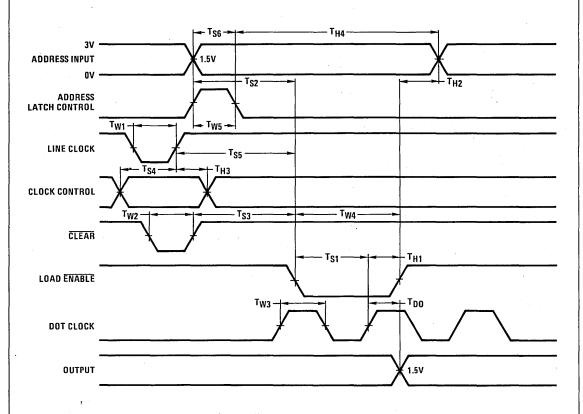
ADDRESS LATCH CONTROL	FUNCTION PERFORMED
0	Latched
1	Fall Through

### B) 4-BIT LINE COUNTER

CLOCK CONTROL	LINE CLOCK	CLEAR	LINE COUNTER
Н		Н	Increment line counter
x '	X	L	Asynchronous clear
			resets counter
L L	X	iн	Clock inhibited
Н .	~~_	Н	No change on high-to-
		ŀ	low clock edge

X = Don't care

# **Switching Time Waveforms**



### **Definitions**

A0-A6: Character address. A 7-bit code which selects 1 of the 128 characters in the font.

Clear: Active low clear for mod 16 row counter, (can be used to truncate mod 16 counter).

Line Clock: Clock that advances the line counter. Advances counter on the low-to-high transition.

Clock Control: Enables line clock when high and disables line clock when low.

Load Enable: Active low load command which routes data from the character ROM to the "D" inputs of the 7-bit shift register.

Dot Clock: A low-to-high transition of the dot clock loads the shift register if load enable is low or shifts data if load enable is high.

Output: A TTL BI-STATE output buffer.

# **Functional Description**

To select a character, a 7-bit binary word must be present at the address inputs A0-A6 when the address latch control is high. This address can be latched by bringing the address latch control signal low after a 40 ns set-up time. When the clear input receives a low pulse, the counter is reset to zero. The shift register can be loaded (TS2 ns) after the character is addressed. Data, representing one horizontal line of the addressed character, is available at the output when the load enable input is brought low. As shown in Figure 1, valid data arrives serially at the output. Dot clock pulses beyond that required to shift out one line of the character will add lows to the end of character. This provides a horizontal spacing between characters.

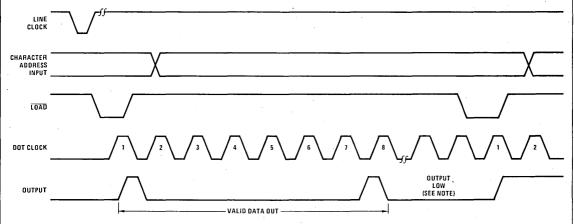
Figure 2 shows how the counter sequences through the rows of addressed lines with the application of clock pulses at the line clock input. Any additional line clocks beyond that required to display the character will put a vertical space between characters. This spacing can be truncated by bringing the clear input low.

A two character display example is shown in Figure 3 and a typical system timing waveform is shown in Figure 4. The standard fonts are shown in Figures 5, 6, 7 and 8. Descending characters in the 5 x 7 fonts are

shifted by virtue of their placement in the matrix. Descending characters in the  $7 \times 9$  fonts are shifted (by th on-chip line shifter/counter) the number of lines indicated by the number in the upper left hand corner of the character drawings in the figures.

Character Cycle — ROM data corresponding to one line of characters is loaded into the shift register TS2 after the ROM is addressed. When load enable goes low, ROM data is allowed to be present at the D input of the shift register via the MUX. The first bit of the ROM data is transferred to the output at the next low-to-high transition of the dot clock. After load enable goes back high, the second to seventh clock pulses shift out the rest of the selected row of the addressed character. Additional clock pulses will shift out low data used for spacing.

Line Cycle — The line counter is a mod 16 counter. A low-to-high transition of the line clock advances the line counter to the next count. If, for any reason, the counts need to be truncated, a low signal at the clear input resets the counter to zero. The clock control may be used as a line clock disable. A high signal at the line clock control terminal enables the counter and a low signal disables the line clock.



Note. Output goes and stays low following the leading edge of the eighth Dot-Clock pulse until Load enable is enabled again and new parallel data is loaded into the shift register.

FIGURE 1. Character Cycle

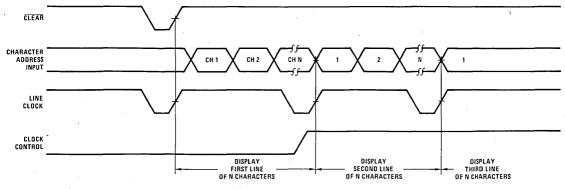


FIGURE 2. Line Cycle

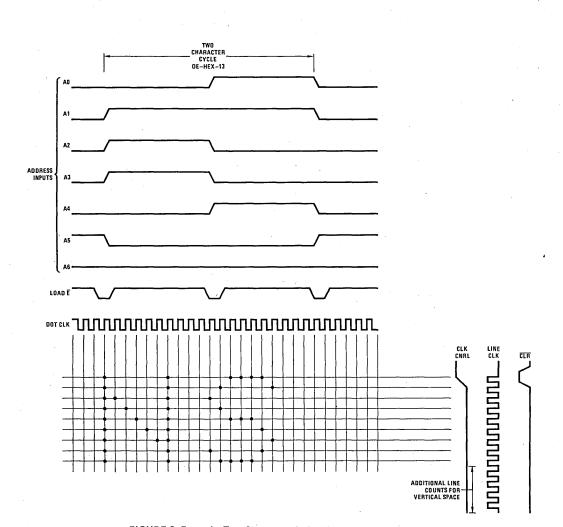
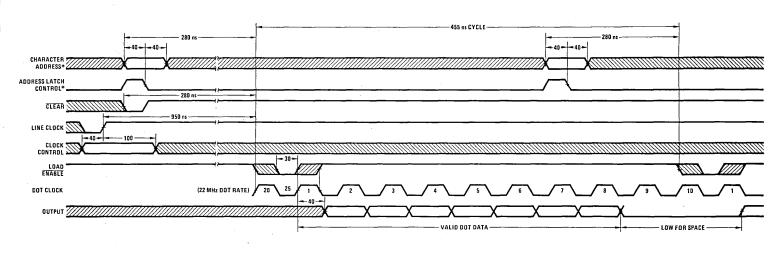


FIGURE 3. Example, Two Character Display Timing - DM86S128CNC





\*Shown here for operation with dynamic memory. For static memory operation the address latch control would be tied high and the character addresses would be stable between each address change occurring 280 ns before the high-to-low transition of Load enable.

FIGURE 4. Typical System Timing Waveform



	00000000	00000000	0=0000000	000000000			00000000	000000000
u.								
u l			000000000 000000000 000000000 00000000					
o								
ပ								
8								
Ą							4 000000000 0000000000 000000000 00000000	
6								
60								
7							4	
9								
us.								
4								
е.								
2								
-								
0								4 
A0-A3	0	-		m	4	ıs	9	

FIGURE 6. DM86S128CND

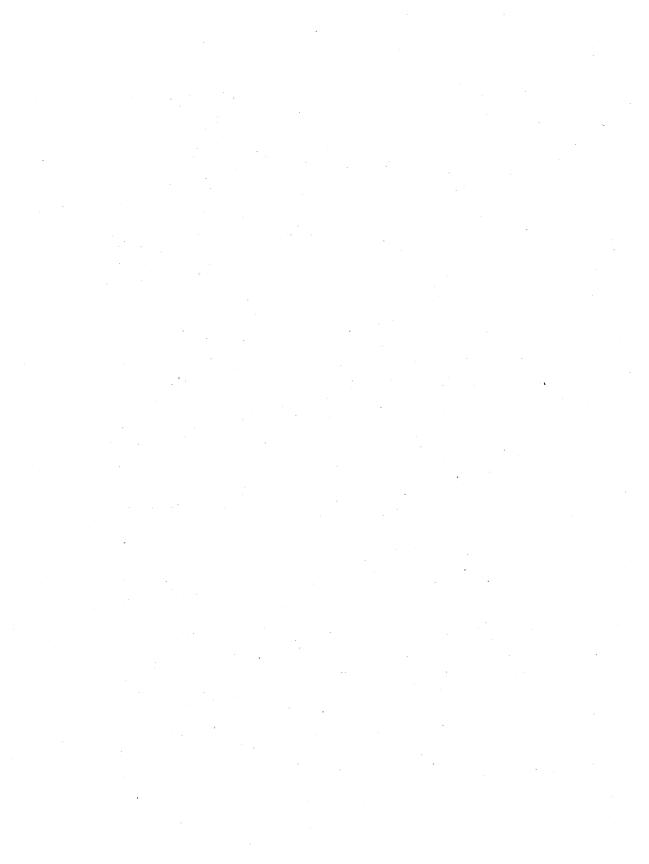
# Functional Description (Continued)

u.								
ш								
Q								
ပ								
ш.								
<b>A</b>				000000000 000000000 00000000 00000000 0000				
6								
<b>60</b>								
,								
9								
us .								
4								
6								
2								
-								
, 0								
A0-A3 A4-A6	0	-	2	m	4	9	<b>w</b>	

ω				
3 8				
A4-A6 0 1				

FIGURE 7. DM86S128CQJ

A0-A3					2 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0
-					
2			00000000000000000000000000000000000000		
- г					
4				00000000 00000000 00000000 00000000	
re.					
9					
,		00000000 0000000 0000000 0000000 000000			
8					
6					
A					
B					
ບ		2 0000000000000000000000000000000000000			
a					
w					
ш.				2 00000000 00000000 000000000 0000000000	

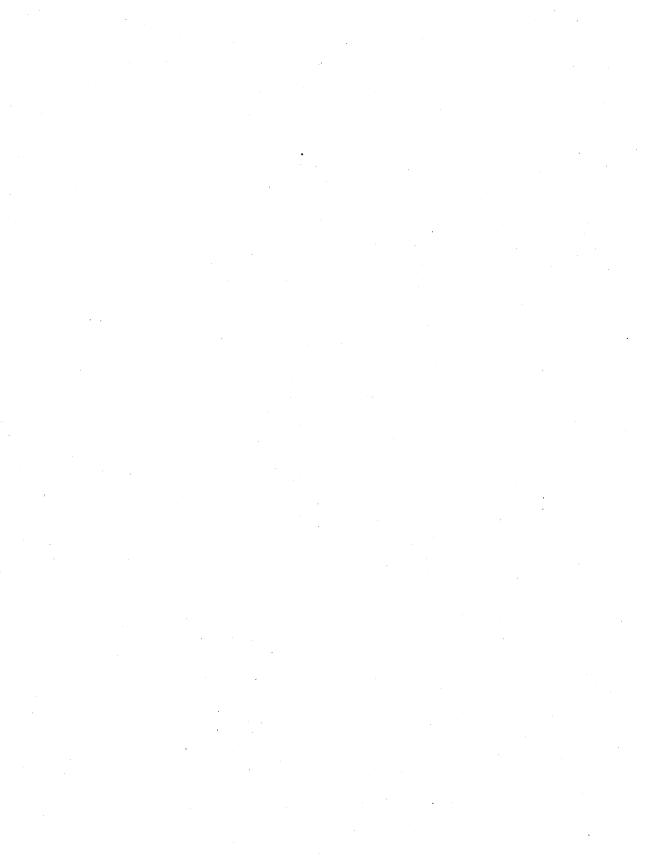




# Section 22 Bipolar and ECL RAMs



DEVICE	DESCRIPTION	PAGE NUMBER
DM54S189/DM74S189	64-Bit (16 × 4) TRI-STATE RAM	22-3
DM54S289/DM74S289	64-Bit Open-Collector RAM	22-3
DM54S189A/DM74S189A	High Speed 64-Bit TRI-STATE RAM	22-3
DM75S06/DM85S06	Open-Collector 64-Bit (16 × 4) RAM	22-10
DM75S07/DM85S07	TRI-STATE 64-Bit (16 × 4) RAM	22-10
DM75S07A/DM85S07A	High Speed TRI-STATE Non-Inverting 64-Bit (16 × 4) RAM	22-10-
DM77S401/DM87S401, DM77S402/DM87S402	First-In, First-Out (FiFo) $64 \times 4$ , $64 \times 5$ Serial Memories	22-16
DM77S401A/DM87S401A, DM77S402A/DM87S402A	First-In, First-Out (FiFo) 64 × 4, 64 × 5 Serial Memories	22-20
DM75S68/DM85S68	16 × 4 Edge Triggered Registers	22-24
IDM29705/29705A	16-Word by 4-Bit Two-Port RAM/Register File	22-27
DM10414, DM10414A	256 × 1 ECL Random Access Memory	22-32
DM10415, DM10415A	1024 × 1 ECL Random Access Memory	22-37
DM10422	1024-Bit (256 × 4) ECL RAM	22-42
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DM10470	Standard 4096-Bit (4096 × 1) ECL RAM	22-48
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DM10470L	Low Power 4096-Bit (4096 x 1) ECL RAM	22-48
DM10474/DM10474A	(1024 × 4) 4096-Bit. 10k ECL RAM	22-53



# **Bipolar and ECL RAMs**

# DM54S189/DM74S189 64-Bit (16 × 4) TRI-STATE® RAM DM54S289/DM74S289 64-Bit Open-Collector RAM DM54S189A/DM74S189A High Speed 64-Bit TRI-STATE RAM

# **General Description**

These 64-bit active-element memories are monolithic Schottky-clamped transistor-transistor logic (TTL) arrays organized as 16 words of 4 bits each. They are fully decoded and feature a chip-enable input to simplify decoding required to achieve the desired system organization. The memories feature PNP input transistors that reduce the low level input current requirement to a maximum of  $-0.25\,\mathrm{mA}$ , only one-eighth that of a DM54S/DM74S standard load factor. The chip-enable circuitry is implemented with minimal delay times to compensate for added system decoding.

The TRI-STATE output combines the convenience of an open-collector with the speed of a totem-pole output; it can be bus connected to other similar outputs; yet it retains the fast rise time characteristics of the TTL totem-pole output. Systems utilizing data bus lines with a defined pull-up impedance can employ the open-collector DM54S289.

Write Cycle: The complement of the information at the data input is written into the selected location when both the chip-enable input and the read/write input are low. While the read/write input is low, the outputs are in the high-impedance.state. When a number of the DM54S189 outputs are bus connected, this high-impedance state will neither load nor drive the bus line, but it will allow the bus line to be driven by another active output or a passive pullup if desired.

Read Cycle: The stored information (complement of information applied at the data inputs during the write cycle) is available at the outputs when the read/write input is high and the chip-enable is low. When the chip-enable is high, the outputs will be in the high-impedance state.

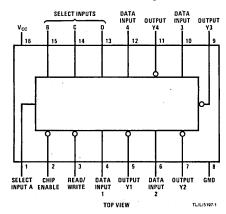
The fast access time of the DM54S189A makes it particularly attractive for implementing high-performance memory functions requiring access times less than 25 ns. The high capacitive drive capability of the outputs permits expansion without additional output buffering. The unique functional capability of the DM54S189A outputs being at a high-impedance during writing, combined with the data inputs being inhibited during reading, means that both data inputs and outputs can be connected to the data lines of a bus-organized system without the need for interface circuits.

### **Features**

- Schottky-clamped for high speed applications (S189A) access from chip-enable input 17 ns max access from address inputs 25 ns max
- TRI-STATE outputs drive bus-organized sýstems and/or high capacitive loads (S189, S189A)
- DM54S289/DM74S289 are functionally equivalent and have open-collector outputs
- DM54SXXX is guaranteed for operation over the full military temperature range of - 55°C to + 125°C
- Compatible with most TTL circuits
- Chip-enable input simplifies system decoding

# **Connection Diagram**

### Dual-In-Line Package



# Truth Table

	Inp	uts	
Function	Chip- Enable	Read/ Write	Output
Write (Store Complement of Data)	L	L	High-Impedance
Read	Ļ	Н	Stored Data
Inhibit	Н	Х	High-Impedance

H = High Level

L = Low Level

X = Don't Care

Order Number DM54S189J, DM54S189AJ, DM74S189J, DM74S189AJ, DM54S289J or DM74S289J See NS Package J16A

Order Number DM74S189N, DM74S189AN or DM74S289N See NS Package N16E

TRI-STATE® is a registered trademark of National Semiconductor Corp.



Absolute Maximum Ratings (Note 1)	Operating Conditions					
		Min	Max	Units		
Supply Voltage, V <sub>CC</sub> 7.0V	Supply Voltage (V <sub>CC</sub> )					
Input Voltage 5.5V	DM54S189, DM54S289	4.5	5.5	V		
Output Voltage 5.5V	DM74S189, DM74S289	4.75	5.25	V		
Storage Temperature Range - 65°C to + 150°C Lead Temperature (Soldering, 10 seconds) 300°C	Temperature (T <sub>A</sub> ) DM54S189, DM54S289 DM74S189, DM74S289	- 55 0	+ 125 + 70	°C °C		

# DM54S189/DM74S189, DM54S289/DM74S289 Electrical Characteristics

over recommended operating free-air temperature range unless otherwise noted (Notes 2 and 3)

Symbol	Parameter		Cond	litions	Min	Тур	Max	Units
V <sub>IH</sub>	High Level Input Voltage				2			٧
V <sub>IL</sub>	Low Level Input Voltage						0.8	٧
V <sub>OH</sub>	High Level Output Voltage	V M:-	I <sub>OH</sub> =	- 2.0 mA, DM54S189	2.4	3.4	,	V
	•	V <sub>CC</sub> = Min	I <sub>OH</sub> =	- 6.5 mA, DM74S189	2.4	3.2		>
I <sub>CEX</sub>	High Level Output Current	V	V <sub>OH</sub> =	= 2.4V			40	
	Open Collector Only	V <sub>CC</sub> = Min	V <sub>OH</sub> =	= 5.5V		·	100	μΑ
VoL	Low Level Output Voltage	V M:- 1	DM54S189, DM54S289 DM74S189, DM74S289				0.5	V
		V <sub>CC</sub> = Min, I <sub>OL</sub> =					0.45	V
l <sub>IH</sub>	High Level Input Current	$V_{CC} = Max, V_I = 2.7V$					25	μΑ
lı	High Level Input Current at Maximum Voltage	$V_{CC} = Max, V_I = 5.5V$					1.0	m/
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max, V <sub>I</sub> =	0.45V				- 250	μΑ
los	Short Circuit Output Current (Note 4)	V <sub>CC</sub> = Max, V <sub>O</sub> =	- 0V	DM54S189, DM74S189	-30		<b>–</b> 100	m/
Icc	Supply Current (Note 5)	V <sub>CC</sub> = Max				75	110	m/
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>I</sub> =	– 18 mA				- 1.2	٧
l <sub>ozн</sub>	TRI-STATE Output Current, High Level Voltage Applied	V <sub>CC</sub> = Max, V <sub>O</sub> =	= 2.4V	DM54S189, DM74S189			50	μΑ
lozu	TRI-STATE Output Current, Low Level Voltage Applied	$V_{CC} = Max, V_O = 0.45V$ DM5		DM54S189, DM74S189	<b>- 50</b>			μΑ
C <sub>IN</sub>	Input Capacitance	V <sub>CC</sub> = 5V, V <sub>IN</sub> = 2V, T <sub>A</sub> = 25°C, 1 MHz				4.0		pF
Со	Output Capacitance	V <sub>CC</sub> = 5V, V <sub>O</sub> = 2 Output "OFF"	$2V, T_A = 2$	25°C, 1 MHz,		6.0		pF

# DM54S189/DM74S189 Switching Characteristics

over recommended operating ranges of TA and VCC unless otherwise noted

	Parameter Access Times from Address		Conditions	DM54S189			DM74S189			]
Symbol				Min	Typ (Note 2)	Max	Min	Typ (Note 2)	Max	Units
t <sub>AA</sub>					25	50		25	35	ns
t <sub>CZH</sub>	Output Enable Time to High Level	Access Times from			12	25		12	17	ns
t <sub>CZL</sub>	Output Enable Time to Low Level	Chip-Enable	$C_L = 30 \text{ pF},$ $R_L = 280\Omega$		12	25		12	17	ns
t <sub>WZH</sub>	Output Enable Time to High Level	Sense Recovery Times	(Figure 4)		13	35		13	25	ns
t <sub>WZL</sub>	Output Enable Time to Low Level	from Read/Write			13	35		13	25	ns

# DM54S189/DM74S189 Switching Characteristics (Continued)

over recommended operating ranges of TA and VCC unless otherwise noted

			DM54S189			DM74S189				
Symbol	Para	ameter	Conditions	Min	Typ (Note 2)	Max	Min	Typ (Note 2)	Max	Units
t <sub>CHZ</sub>	Output Disable Time from High Level	Disable Times from			12	25		12	17	ns
t <sub>CLZ</sub>	Output Disable Time from Low Level	Chip-Enable	$C_L = 5 \text{ pF},$ $R_1 = 280\Omega$	-	12	25		12	17	ns
t <sub>WHZ</sub>	Output Disable Time from High Level	Disable Times from	(Figure 4)		15	35		15	25	ns
t <sub>WLZ</sub>	Output Disable Time from Low Level	Read/Write			15	35		15	25	ns
t <sub>WP</sub>	Width of Write Enable I	Pulse (Read/Write Low)		25			25			ns
tASW	Set-Up Time (Figure 1)	Address to Read/Write		0			0			ns
t <sub>DSW</sub>		Data to Read/Write		25			25			ns
t <sub>CSW</sub>		Chip-Enable to Read/Write		0	·		0			ns
t <sub>AHW</sub>	Hold Time (Figure 1)	Address from Read/Write		0			0			ns
t <sub>DHW</sub>		Data from Read/Write		0			0			ns
t <sub>CHW</sub>		Chip-Enable from Read/Write		0			0			ns

# DM54S289/DM74S289 Switching Characteristics

over recommended operating ranges of TA and VCC unless otherwise noted

			.		DM54S28	9		DM74S28	9	
Symbol	Par	Parameter ·		Min	Typ (Note 2)	Max	Min	Typ (Note 2)	Max	Units
t <sub>AA</sub>	Access Times from Ad	dress			25	50		25	35	ns
t <sub>CHL</sub>	Enable Time from Chip-Enable		C <sub>L</sub> = 30 pF,		12	25		12	17	ns
t <sub>WHL</sub>	Enable Time from Read/Write	Sense Recovery Time from Read/Write	$R_{L1} = 300\Omega,$ $R_{L2} = 600\Omega$ $(Figure 4)$		13	35		13	25	ns
t <sub>CLH</sub>	Disable Time from Chip-Enable				12	25		12	20	ns
t <sub>WLH</sub>	Disable Time from Read/Write				13	35		13	25	ns
t <sub>WP</sub>	Width of Write Enable	Pulse (Read/Write Low)		25			25			ns
t <sub>ASW</sub>	Set-Up Time (Figure 2)	Address to Read/Write		0			0			ns
t <sub>DSW</sub>		Data to Read/Write	•	25			25			ns
t <sub>CSW</sub>		Chip-Enable to Read/Write		0			0			ns
t <sub>AHW</sub>	Hold Time (Figure 2)	Address from Read/Write		0			0			ns
t <sub>DHW</sub>		Data from Read/Write		0			0			ns
t <sub>CHW</sub>		Chip-Enable from Read/Write		0			0			ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DM54S189/289 and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DM74S189/289. All typicals are given for V<sub>CC</sub> = 5.0V and T<sub>A</sub> = 25°C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: ICC is measured with all inputs grounded; and the outputs open.

Absolute Maximum Ratings	(Note 1)	Operating Conditions					
			Min	Max	Units		
Supply Voltage, V <sub>CC</sub>	7.0V	Supply Voltage (V <sub>CC</sub> )					
Input Voltage	5.5V	DM54S189(A)/DM54S289	4.5	5.5	٧		
Output Voltage	5.5V	DM74S189(A)/DM74S289	4.75	5.25	٧		
Storage Temperature Range -6	5°C to + 150°C	Temperature (T <sub>A</sub> ) DM54S189(A)/DM54S289	<b>–</b> 55	+ 125	°C		
Lead Temperature (Soldering, 10 seconds)	300°C	DM74S189(A)/DM74S289	0	+ 70	°C		

### DM54S189A/DM74S189A Electrical Characteristics

over recommended operating free-air temperature range unless otherwise noted (Notes 2 and 3)

Symbol	Parameter	C	onditions		Min	Тур	Max	Units
V <sub>IH</sub>	High Level Input Voltage				2			ν
V <sub>IL</sub>	Low Level Input Voltage						0.8	V
V <sub>OH</sub>	High Level Output Voltage	I <sub>OH</sub> =	= - 2.0 mA	DM54S189A	2.4	3.4		V
		$V_{CC} = Min I_{OH} = I_{OH}$	= - 6.5 mA	DM74S189A	2.4	3.2		] <b>v</b>
V <sub>OL</sub>	Low Level Output Voltage	I <sub>OL</sub> =	: 16 mA				0.45	V
	,	$V_{CC} = Min \frac{I_{OL} = I_{OL}}{I_{OL}}$	: 20 mA	•			0.5	]
I <sub>IH</sub>	High Level Input Current	$V_{CC} = Max, V_I = 3$			10	μΑ		
l <sub>l</sub> ·	High Level Input Current at Maximum Voltage	V <sub>CC</sub> = Max, V <sub>I</sub> = 5.5V					1.0	mA
I <sub>IL</sub>	Low Level Input Current	$V_{CC} = Max, V_1 = 0$			- 250	μΑ		
Ios	Short Circuit Output Current (Note 4)	$V_{CC} = Max, V_O = 0V$			- 20		- 90	mA ,
Icc	Supply Current (Note 5)	V <sub>CC</sub> = Max				75	100	mA
V <sub>IC</sub>	Input Clamp Voltage	$V_{CC} = Min, I_I = -$	18 mA				- 1.2	٧
l <sub>ozh</sub>	TRI-STATE Output Current, High Level Voltage Applied	$V_{CC} = Max, V_O =$	2.4V				40	μΑ
l <sub>OZL</sub>	TRI-STATE Output Current, Low Level Voltage Applied	$V_{CC} = Max, V_O = 0.4V$		- 40			μΑ	
C <sub>IN</sub>	Input Capacitance	$V_{CC} = 5V, V_{IN} = 2$	V, T <sub>A</sub> = 25°C	, 1 MHz		4.0		pF
Co	Output Capacitance	V <sub>CC</sub> = 5V, V <sub>O</sub> = 2 Output "OFF"	V, T <sub>A</sub> = 25°C,	, 1 MHz,		6.0		pF

over recommended operating ranges of TA and VCC unless otherwise noted

			_ C	M54S189	Α	[				
Symbol	Par	ameter	Conditions	Min	Typ (Note 2)	Max	Min	Typ (Note 2)	Max	Units
t <sub>AA</sub>	Access Times from Add	dress			20	30		20	25	ns
t <sub>CZH</sub>	Output Enable Time to High Level	Access Times from			11	25		11	17	ns
t <sub>CZL</sub>	Output Enable Time to Low Level	Chip-Enable	$C_L = 30 \text{ pF},$ $R_L = 280\Omega$ (Figure 4)		11	25		11	17	ns
t <sub>WZH</sub>	Output Enable Time to High Level	Sense Recovery Times			13	35		13	25	ns
t <sub>WZL</sub>	Output Enable Time to Low Level	from Read/Write			13	35		13	25	ns
t <sub>CHZ</sub>	Output Disable Time from High Level	Disable Times from			12	25		12	17	ns
t <sub>CLZ</sub>	Output Disable Time from Low Level	Chip-Enable	$C_L = 5 \text{ pF},$ $R_1 = 280\Omega$		12	25		12	17	ns
t <sub>WHZ</sub>	Output Disable Time from High Level	Disable Times from	(Figure 4)		15	35		. 15	25	ns
t <sub>WLZ</sub>	Output Disable Time from Low Level	Read/Write	,		15	35		15	25	ns
t <sub>WP</sub>	Width of Write Enable F	Pulse (Read/Write Low)		25			20			ns
$t_{ASW}$	Set-Up Time (Figure 1)	Address to Read/Write		0	·	<u> </u>	0			ns
tosw		Data to Read/Write		25			20			ns
t <sub>CSW</sub>		Chip-Enable to Read/Write		0			0			ns
t <sub>AHW</sub>	Hold Time (Figure 1)	Address from Read/Write		0			0			ns
$t_{DHW}$		Data from Read/Write		0			0			ns
t <sub>CHW</sub>		Chip-Enable from Read/Write		0			0			ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DM54S189(A) and across the 0°C to +70°C range for the DM74S189(A). All typicals are given for V<sub>CC</sub> = 5.0V and T<sub>A</sub> = 25°C.

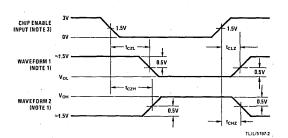
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

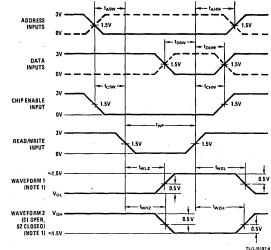
Note 5: ICC is measured with all inputs grounded; and the outputs open.

# DM54S189(A)/DM74S189(A) Switching Time Waveforms

### **Enable and Disable Time from Chip-Enable**



### Write Cycle



Access Time from Address Inputs

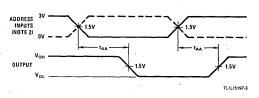


FIGURE 1

Note 1: Waveform 1 is for the output with internal conditions such that the output is low except when disabled. Waveform 2 is for the output with internal conditions such that the output is high except when disabled.

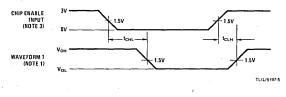
Note 2: When measuring delay times from address inputs, the chip-enable input is low and the read/write input is high,

Note 3: When measuring delay times from chip-enable input, the address inputs are steady-state and the read/write input is high.

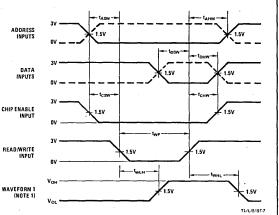
Note 4: Input waveforms are supplied by pulse generators having the following characteristics: t<sub>f</sub>≤2.5 ns, t<sub>f</sub>≤2.5 ns, PRR≤1 MHz and Z<sub>OUT</sub>≈50Ω.

# DM54S289/DM74S289 Switching Time Waveforms

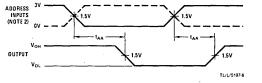
#### **Enable and Disable Time from Chip-Enable**



#### Write Cycle



### Access Time from Address Inputs



#### FIGURE 2

Note 1: Waveform 1 is for the output with internal conditions such that the output is low except when disabled.

Note 2: When measuring delay times from address inputs, the chip-enable input is low and the read/write input is high.

Note 3: When measuring delay times from chip-enable input, the address inputs are steady-state and the read/write input is high.

Note 4: Input waveforms are supplied by pulse generators having the following characteristics:  $t_{\Gamma} \le 2.5 \text{ ns}, t_{\bar{\Gamma}} \le 2.5 \text{ ns}, t_{\bar{\Gamma}} \le 2.5 \text{ ns}, t_{\bar{\Gamma}} \le 2.5 \text{ ns}$ 

# **Block Diagram**

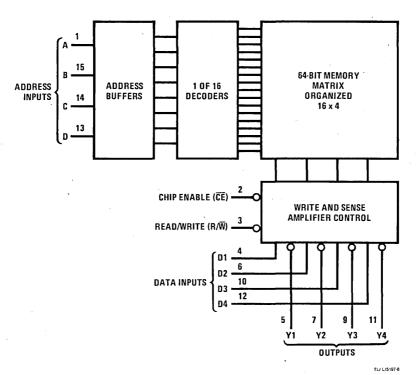
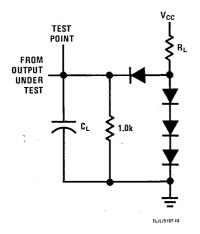


FIGURE 3

# **AC Test Circuits**

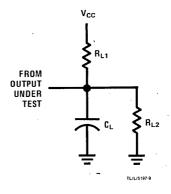
### DM54S189(A)/DM74S189(A)



 $C_L$  includes probe and jig capacitance. All diodes are 1N3064.  $\dot{\ }$ 

FIGURE 4

### DM54S289/DM74S289





# **Bipolar and ECL RAMs**

# DM75S06/DM85S06 Open-Collector DM75S07/DM85S07 TRI-STATE DM75S07A/DM85S07A High Speed TRI-STATE Non-Inverting, 64-Bit (16 × 4) RAMs

# **General Description**

These 64-bit active-element memories are monolithic Schottky-clamped transistor-transistor logic (TTL) arrays organized as 16 words of 4 bits each. They are fully decoded and feature a chip-enable input to simplify decoding required to achieve the desired system organization. The memories feature PNP input transistors that reduce the low level input current requirement to a maximum of  $-0.25\,\text{mA}$ , only one-eighth that of a DM54S/DM74S standard load factor. The chip-enable circuitry is implemented with minimal delay times to compensate for added system decoding.

The TRI-STATE output combines the convenience of an open-collector with the speed of a totem-pole output; it can be bus-connected to other similar outputs; yet it retains the fast rise time characteristics of the TTL totempole output. Systems utilizing data bus lines with a defined pull-up impedance can employ the open-collector DM75S06.

Write Cycle: The information at the data input is written into the selected location when both the chip-enable input and the read/write input are low. While the read/write input is low, the outputs are in the high-impedance state. When a number of the DM85S07 outputs are bus-connected, this high-impedance state will neither load nor drive the bus line, but it will allow the bus line to be driven by another active output or a passive pull-up if desired.

Read Cycle: The stored information is available at the outputs when the read/write input is high and the chip-

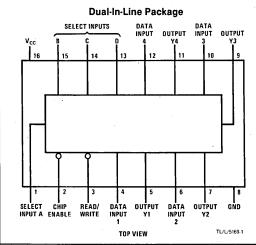
enable is low. When the chip-enable is high, the outputs will be in the high-impedance state.

The fast access time of the DM75S07A makes it particularly attractive for implementing high-performance memory functions requiring access times less than 25 ns. The high capacitive drive capability of the outputs permits expansion without additional output buffering. The unique functional capability of the DM75S07 outputs being at a high-impedance during writing, combined with the data inputs being inhibited during reading, means that both data inputs and outputs can be connected to the data lines of a bus-organized system without the need for interface circuits.

### **Features**

- Schottky-clamped for high speed applications (75S07A)
   access from chip-enable input
   17 ns max
   access from address inputs
   25 ns max
- TRI-STATE outputs drive bus-organized systems and/or high capacitive loads
- DM75S06, DM85S06 are functionally equivalent and have open-collector outputs
- DM75SXX is guaranteed for operation over the full military temperature range of -55°C to +125°C
- Compatible with most TTL logic circuits
- Chip-enable input simplifies system decoding

# **Connection Diagram**



# **Truth Table**

	Inp	uts	
Function	Chip- Enable	Read/ Write	Output
Write	L	L	High-Impedance
Read	L L	Н	Stored Data
Inhibit	Н	Х	High-Impedance

H = High Level

L = Low Level

X = Don't Care

Order Number DM75S06J, DM75S07J, DM75S07AJ, DM85S06J, DM85S07J or DM85S07AJ See NS Package J16A

Order Number DM85S06N, DM85S07N or DM85S07AN See NS Package N16E

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<b>Absolute Maximum Rating</b>	<b>]S</b> (Note 1)	Operating Conditions						
			Min	Max	Units			
Supply Voltage, V <sub>CC</sub>	7.0V	Supply Voltage (V <sub>CC</sub> )						
Input Voltage	5.5V	DM75S06/DM75S07(A)	4.5	5.5	V			
Output Voltage	5.5V	DM85S06/DM85S07(A)	4.75	5.25	V			
	-65°C to +150°C s) 300°C	Temperature (T <sub>A</sub> ) DM75S06/DM75S07(A) DM85S06/DM85S07(A)	- 55 0	+ 125 + 70	ဗင			

**Electrical Characteristics** over recommended operating free-air temperature range unless otherwise noted (Notes 2 and 3)

	<del>  </del>				<del> </del>		<del></del>
Symbol	ymbol Parameter		Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	High Level Input Voltage			2			V
$V_{IL}$	Low Level Input Voltage					0.8	V
$V_{OH}$	High Level Output Voltage	V - Min	$I_{OH} = -2.0 \text{ mA}, DM75S07(A)$	2.4	3.4		v ·
		V <sub>CC</sub> = Min	$I_{OH} = -5.2 \text{ mA}, DM85S07(A)$	2.4	3.2		٧
I <sub>CEX</sub>	High Level Output Current Open-Collector Only	V <sub>CC</sub> = Min	V <sub>OH</sub> = 2.4V			40	μΑ
			V <sub>OH</sub> = 5.5V			100	μΑ
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min	I <sub>OL</sub> = 16 mA			0.45	V
			I <sub>OL</sub> = 20 mA			0.5	V
I <sub>IH</sub>	High Level Input Current	V <sub>CC</sub> = Max,		1	10	μΑ	
I <sub>I</sub>	High Level Input Current at Maximum Voltage	V <sub>CC</sub> = Max, V <sub>I</sub> = 5.5V				1.0	mA
l <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max,			- 250	μΑ	
los	Short Circuit Output Current (Note 4)	V <sub>CC</sub> = Max, V <sub>O</sub> = 0V DM75S07(A), DM85S07(A)		-30		- 90	mA
Icc	Supply Current (Note 5)	V <sub>CC</sub> = Max			75	100	. mA
V <sub>IC</sub>	Input Clamp Voltage	$V_{CC} = Min, I_1 = -18 \text{ mA}$				- 1.2	V
I <sub>OZH</sub>	TRI-STATE Output Current, High Level Voltage Applied	V <sub>CC</sub> = Max, V <sub>O</sub> = 2.4V DM75S07(A), DM85S07(A)				40	μА
I <sub>OZL</sub>	TRI-STATE Output Current, Low Level Voltage Applied	V <sub>CC</sub> = Max, V <sub>O</sub> = 0.4V DM75S07(A), DM85S07(A)		- 40			μА
CiN	Input Capacitance	V <sub>CC</sub> = 5V, V		4		pF	
Co	Output Capacitance	V <sub>CC</sub> = 5V, V Output "Of		6		pF	

# DM75S07/DM85S07 Switching Characteristics over recommended operating ranges of $T_A$ and $V_{CC}$ unless otherwise noted

	Parameter Access Times from Address		Conditions	DM75S07			DM85S07			
Symbol				Min	Typ (Note 1)	Max	Min	Typ (Note 1)	Max	Units
t <sub>AA</sub>					25	50		25	35	
t <sub>CZH</sub>	Output Enable Time to High Level	Access Times from Chip-Enable			12	25		12	17	ns
t <sub>CZL</sub>	Output Enable Time to Low Level		$C_L = 30 \text{ pF},$ $R_L = 280\Omega$ (Figure 4)		12	25		12	17	ns
t <sub>WZH</sub>	Output Enable Time to High Level	Sense Recovery Times from Read/Write			13	35		13	25	ns
t <sub>WZL</sub>	Output Enable Time to Low Level				13	35		13	25	ns
t <sub>CHZ</sub>	Output Disable Time from High Level	Disable Times from Chip-Enable	C <sub>L</sub> = 5 pF, R <sub>L</sub> = 280Ω (Figure 4)		12	25		12	17	ns
t <sub>CLZ</sub>	Output Disable Time from Low Level				12	25		12	17	ns
t <sub>WHZ</sub>	Output Disable Time from High Level	Disable Times from Read/Write			15	35		15	25	ns
t <sub>WLZ</sub>	Output Disable Time from Low Level				15	35		15	25	ns
t <sub>WP</sub>	Width of Write Enable Pulse (Read/Write Low)			25			25			ns
tASW	Set-Up Time (Figure 1)	Address to Read/Write		0			0			ns
$t_{\text{DSW}}$		Data to Read/Write		25			25			ns
t <sub>CSW</sub>		Chip-Enable to Read/Write		0			0			ns
t <sub>AHW</sub>	Hold Time (Figure 1)	Address from Read/Write		0			0			ns
$t_{\text{DHW}}$		Data from Read/Write		0			0			ns
t <sub>CHW</sub>		Chip-Enable from Read/Write		0			0			ns

# DM75S07A/DM85S07A Switching Characteristics

over recommended operating ranges of TA and VCC unless otherwise noted

Symbol	Parameter		Conditions	DM75S07A			DM85S07A			
				Min	Typ (Note 1)	Max	Min	Typ (Note 1)	Max	Units
tAA	Access Times from Ad	Access Times from	C <sub>L</sub> = 30 pF, R <sub>L</sub> = 280Ω (Figure 4)		20	30		20	25	ns
t <sub>CZH</sub>	Output Enable Time to High Level				12	25		12	17	ns
t <sub>CZL</sub>	Output Enable Time to Low Level				12	25		12	17	ns
t <sub>WZH</sub>	Output Enable Time to High Level	Sense Recovery Times			13	35		13	25	ns
t <sub>WZL</sub>	Output Enable Time to Low Level				13	35		13	25	ns

## A Switching Characteristics (Continued)

over recommended operating ranges of TA and VCC unless otherwise noted

				ı	OM75S07/	۹.	DM85S07A			
Symbol	Paramet	ter ·	Conditions	Min	Typ (Note 1)	Max	Min	Typ (Note 1)	Max	Units
t <sub>CHZ</sub>	Output Disable Time from High Level	Disable Times from			12	25		12	17	ns
t <sub>CLZ</sub>	Output Disable Time from Low Level		$C_L = 5 pF,$ $R_L = 280\Omega$		12	25		12	17	ns
t <sub>WHZ</sub>	Output Disable Time from High Level		(Figure 4)		15	35		15	25	ns
t <sub>WLZ</sub>	Output Disable Time from Low Level				15	35		15	25	ns
t <sub>WP</sub>	Width of Write Enable I	Pulse (Read/Write Low)		25			20	-		ns
tasw	Set-Up Time (Figure 1)	Address to Read/Write		0			0			ns
tosw		Data to Read/Write		25			20			ns
t <sub>CSW</sub>		Chip-Enable to Read/Write	٠	0			0			ns
t <sub>AHW</sub>	Hold Time (Figure 1)	Address from Read/Write		0			0			ns
tohw		Data from Read/Write		0			0			ns
t <sub>CHW</sub>		Chip-Enable from Read/Write		0			0			ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

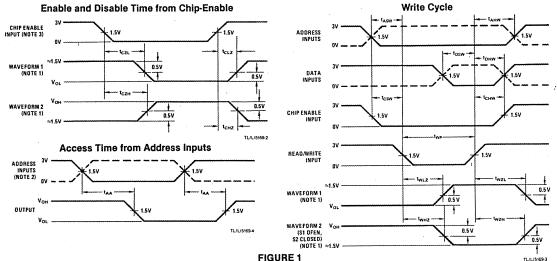
Note 2: Unless otherwise specified min/max limits apply across the -55°C to +125°C temperature range for the DM75S07(A) and across the 0°C to +70°C range for the DM85S07(A). All typicals are given for V<sub>CC</sub> = 5.0V and T<sub>A</sub> = 25°C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: ICC is measured with all inputs grounded; and the outputs open.

# DM75S07(A)/DM85S07(A) Switching Time Waveforms



te 1: Waveform 1 is for the output with internal conditions such that the output is low except when disabled. Waveform 2 is for the output with internal conions such that the output is high except when disabled.

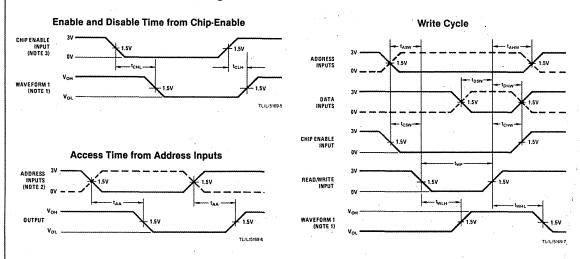
- te 2: When measuring delay times from address inputs, the chip-enable input is low and the read/write input is high.
- le 3: When measuring delay times from chip-enable input, the address inputs are steady-state and the read/write input is high-
- e 4: Input waveforms are supplied by pulse generators having the following characteristics: t<sub>f</sub>≤2.5 ns, t<sub>f</sub>≤2.5 ns, PRR≤1 MHz and Z<sub>QUT</sub>≈50Ω.

## DM75S06/DM85S06 Switching Characteristics

over recommended operating ranges of TA and VCC unless otherwise noted

					DM75S06	3	<u> </u>	DM85S06	,	
Symbol	Parame	Parameter		Min	Typ (Note 1)	Max	Min	Typ (Note 1)	Max	Units
t <sub>AA</sub>	Access Times from Ad	dress	·		25	50		25	35	ns
t <sub>CHL</sub>	Enable Time from Chip-Enable		C <sub>L</sub> = 30 pF,		- 12	25		12	. 17	ns
t <sub>WHL</sub>	Enable Time from Read/Write	Sense Recovery Time from Read/Write	$R_{L1} = 300\Omega$ , $R_{L2} = 600\Omega$ (Figure 4)		13	35		13	25	ns
t <sub>CLH</sub>	Disable Time from Chip-Enable		,		12	25		12	20	ns
t <sub>WLH</sub>	Disable Time from Read/Write			,	13	35		13	25	ns
t <sub>WP</sub>	Width of Write Enable I	Pulse (Read/Write Low)		25			25			ns
tASW	Set-Up Time (Figure 2)	Address to Read/Write		0			0			ns
t <sub>DSW</sub>		Data to Read/Write		25			25			ns
t <sub>CSW</sub>		Chip-Enable to Read/Write		0			0			ns
t <sub>AHW</sub>	Hold Time (Figure 2)	Address from Read/Write		0			0			ns
$t_{\text{DHW}}$		Data from Read/Write		0			0			ns
t <sub>CHW</sub>		Chip-Enable from Read/Write		0			0			ns

# DM75S06/DM85S06 Switching Time Waveforms



#### FIGURE 2

- Note 1: Waveform 1 is for the output with Internal conditions such that the output is low except when disabled.
- Note 2: When measuring delay times from address inputs, the chip-enable input is low and the read/write input is high.
- Note 3: When measuring delay times from chip-enable input, the address inputs are steady-state and the read/write input is high.
- Note 4: Input waveforms are supplied by pulse generators having the following characteristics: tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, tr < 2.5 ns, t

## DM75S07A/DM85S07A Switching Characteristics (Continued)

over recommended operating ranges of TA and VCC unless otherwise noted

				I	DM75S07	4	1			
Symbol	Parame	ter	Conditions	Min	Typ (Note 1)	Max	Min	Typ (Note 1)	Max	Units
t <sub>CHZ</sub>	Output Disable Time from High Level	Disable Times from			12	25		12	17	ns
t <sub>CLZ</sub>	Output Disable Time from Low Level	Chip-Enable	$C_L = 5 pF,$ $R_1 = 280\Omega$		12	25		12	17	ns
t <sub>WHZ</sub>	Output Disable Time from High Level	Disable Times from	(Figure 4)		15	35		15	25	ns
t <sub>WLZ</sub>	Output Disable Time from Low Level	Read/Write			15	35		15	25	ns
t <sub>WP</sub>	Width of Write Enable I	Pulse (Read/Write Low)		25			20	,		ns
tASW	Set-Up Time (Figure 1)	Address to Read/Write		0			0			ns
tosw	al	Data to Read/Write		25			20		**	ns
t <sub>CSW</sub>		Chip-Enable to Read/Write		0			0			ns
t <sub>AHW</sub>	Hold Time (Figure 1)	Address from Read/Write		0			0			ns
tohw		Data from Read/Write		0			0			ns
t <sub>CHW</sub>		Chip-Enable from Read/Write		0			0			ns

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

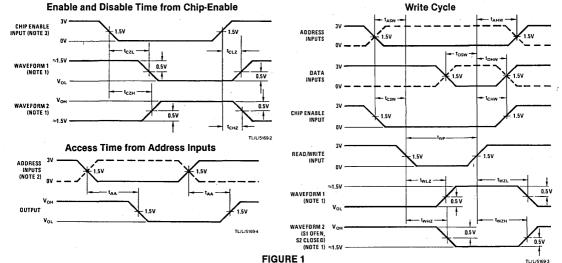
Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DM75S07(A) and across the  $0^{\circ}$ C to  $+70^{\circ}$ C range for the DM85S07(A). All typicals are given for  $V_{CC} = 5.0V$  and  $T_{A} = 25^{\circ}$ C.

Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

Note 5: ICC is measured with all inputs grounded; and the outputs open.

# DM75S07(A)/DM85S07(A) Switching Time Waveforms



Note 1: Waveform 1 is for the output with internal conditions such that the output is low except when disabled. Waveform 2 is for the output with internal conditions such that the output is high except when disabled.

Note 2: When measuring delay times from address inputs, the chip-enable input is low and the read/write input is high.

Note 3: When measuring delay times from chip-enable input, the address inputs are steady-state and the read/write input is high.

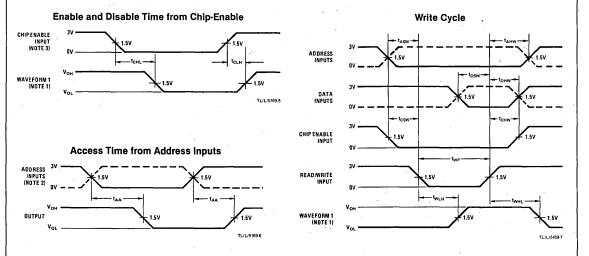
Note 4: Input waveforms are supplied by pulse generators having the following characteristics: t<sub>f</sub> ≤ 2.5 ns, t<sub>f</sub> ≤ 2.5 ns, PRR ≤ 1 MHz and Z<sub>OUT</sub> ≈ 50Ω.

## DM75S06/DM85S06 Switching Characteristics

over recommended operating ranges of TA and VCC unless otherwise noted

	•			DM75S06						
Symbol	Parame	oter	Conditions	Min	Typ (Note 1)	Max	Min	Typ (Note 1)	Max	Units
t <sub>AA</sub>	Access Times from Ad	dress		,	25	50		25	35	ns
t <sub>CHL</sub>	Enable Time from Chip-Enable		C <sub>L</sub> = 30 pF,		12	-25		12	17	ns
t <sub>WHL</sub>	Enable Time from Read/Write	Sense Recovery Time from Read/Write	$R_{L1} = 300\Omega$ , $R_{L2} = 600\Omega$ (Figure 4)		13	35		13	25	ns
t <sub>CLH</sub>	Disable Time from Chip-Enable				12	25		12	20	ns
t <sub>WLH</sub>	Disable Time from Read/Write			,	13	35		13	25	ns
t <sub>WP</sub>	Width of Write Enable I	Pulse (Read/Write Low)		25			25			ns
tASW	Set-Up Time (Figure 2)	Address to Read/Write		0			0			ns
t <sub>DSW</sub>		Data to Read/Write		25			25			ns
t <sub>CSW</sub>		Chip-Enable to Read/Write		0			0			ns
t <sub>AHW</sub>	Hold Time (Figure 2)	Address from Read/Write		0			0			ns
t <sub>DHW</sub>		Data from Read/Write		0			0			ns
t <sub>CHW</sub>		Chip-Enable from Read/Write		0			0			ns

# DM75S06/DM85S06 Switching Time Waveforms



#### FIGURE 2

- Note 1: Waveform 1 is for the output with internal conditions such that the output is low except when disabled.
- Note 2: When measuring delay times from address inputs, the chip-enable input is low and the read/write input is high.
- Note 3: When measuring delay times from chip-enable input, the address inputs are steady-state and the read/write input is high.
- Note 4: Input waveforms are supplied by pulse generators having the following characteristics: tr≤2.5 ns, tr≤2.5 ns, PRR≤1 MHz and Z<sub>OUT</sub>≈50Ω.

# **Block Diagram**

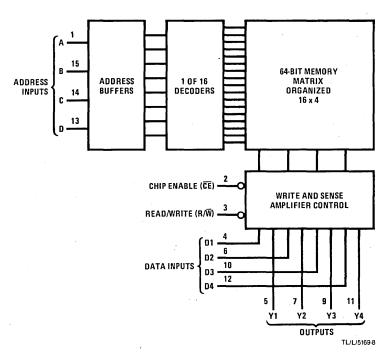
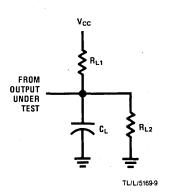


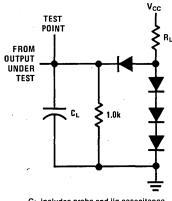
FIGURE 3

## **AC Test Circuits**

#### DM75S06/DM85S06



#### DM75S07(A)/DM85S07(A)



C<sub>L</sub> includes probe and jig capacitance. All diodes are 1N3064.

TL/L/5169-10

### FIGURE 4



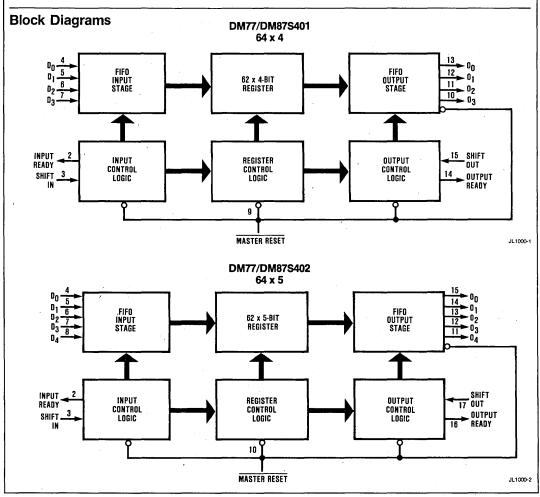
# **Bipolar and ECL RAMs**

# DM77S401/DM87S401, DM77S402/DM87S402 First-In, First-Out (FiFo) 64 x 4, 64 x 5 Serial Memories

The DM77S401 is an expandable "fall-through" type high-speed First-in, First-out (FiFo) memory organized in 64-word by 4-bit, and 64-word by 5-bit structures respectively. A 10 MHz data rate allows usage in high-speed disc or tape controllers as well as PCM and communications buffer applications.

### **Features**

- 10 MHz shift in, shift out
- TTL inputs and outputs
- Inputs and outputs are symmetrically placed on package
- Easily expandable word and bit dimensions
- Either synchronous or asynchronous operation
- Fairchild F3341 MOS FiFo pin compatible but many times faster!
- Choice of 4-bit or 5-bit data width



## **Absolute Maximum Ratings**

Supply Voltage, Vcc 7 Volts
Input Voltage 7 Volts
Off-State Output Voltage 5.5 Volts
Storage Temperature -65° to +150° C

## Electrical Characteristics Over Operating Conditions DM77/DM87S401; DM77/DM87S402

Symbol	Parameter	Cond	Conditions		Тур	Max	Units
V <sub>IL</sub>	Low-Level Input Voltage					0.8	·V
V <sub>IH</sub>	High-Level Input Voltage			2			V
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min,	I <sub>I</sub> = -18mA			-1.5	V
l <sub>IL</sub>	Low-Level D <sub>0</sub> -D <sub>4</sub> , MR Input Current	V <sub>CC</sub> = Max,	V <sub>I</sub> = 0.45V			-0.4	mA
I <sub>IH</sub>	High-Level Input Current	V <sub>CC</sub> = Max,	V <sub>I</sub> = 2.4V			50	μΑ
l <sub>l</sub>	Maximum Input Current	V <sub>CC</sub> = Max,	V <sub>I</sub> = 5.5V			1.0	mA
V <sub>OL</sub>	Low-Level Output Voltage	$V_{CC} = Min$ $V_{IL} = 0.8V$ $V_{IH} = 2V$	I <sub>OL</sub> = 8mA			0.5	V
V <sub>OH</sub>	High-Level Output Voltage	$\begin{array}{c} V_{CC} = Min \\ V_{IL} = 0.8V \\ V_{IH} = 2V \end{array}$	I <sub>OH</sub> = -0.9mA	2.4			V
los	Output Short-Circuit Current (Note 1)	V <sub>CC</sub> = Max,	$V_0 = 0V$	-20		-90	mA
lcc	Supply Current	V <sub>CC</sub> = Max Inputs Low, Outputs Open	DM77S401 DM87S401 DM77S402 DM87S402			190 160 210 180	mA

# **Operating Conditions**

			M77S40	1/402				
Symbol	Parameter	Min	Nom	Max	Min	Nom	Max	Units
V <sub>CC</sub>	Supply Voltage	4.5	5	5.5	4.75	5	5.25	V
T <sub>A</sub>	Operating Free-Air Temperature (Note 2)	-55	-	+125	0		+75	°C
t <sub>SIH</sub>	Shift In HIGH Time	45	15		35	15	ļ	ns
t <sub>SIL</sub>	Shift In LOW Time	45	22		35	22		ns
t <sub>IDS</sub>	Input Data Setup	10	- 9		0	-9		ns
t <sub>IDH</sub>	Input Data Hold Time	55	30		45	30		ns
tson	Shift Out HIGH Time	45	15		35	15		ns
t <sub>SOL</sub>	Shift Out LOW Time	45	15		35	15		ns
t <sub>MRW</sub>	Master Reset Pulse (Note 3)	40	15		35	15		ns
t <sub>MRS</sub>	Master Reset to SI	45	15		35	15		ns

Note 1: Not more than one output should be shorted at a time and duration of the short-circuit should not exceed one second.

Note 2: Case temperature.

Note 3: Master reset clears all the cells to the empty state, and the data outputs to a LOW state.

## Switching Characteristics Over Operating Conditions

	1		M77S40	1/402		1.		
Symbol	Parameter	Min	Тур	Max	Min	Тур	Max	Units
f <sub>IN</sub>	Shift In Rate	7	16		10	16		MHz
t <sub>IRL</sub>	Shift In to Input Ready LOW		30	60		30	45	ns
t <sub>IRH</sub> *	Shift In to Input Ready HIGH		33	60		33	45	ns
four	Shift Out Rate	7	16		10	16		MHz
torl	Shift Out to Output Ready LOW		40	65		40	55	ns
torn**	Shift Out to Output Ready HIGH		45	70		45	60	ns
t <sub>OD</sub> ++	Output Data Delay		38	65		38	55	ns
t <sub>PT</sub>	Data Throughput or "Fall Through"		1.8	4		1.8	3	μS
tMRORL	Master Reset to OR LOW		30	65		30	60	ns
t <sub>MRIRH</sub>	Master Reset to IR HIGH		30	65		30	60	ns
t <sub>IPH</sub>	Input Ready Pulse HIGH	15	22		15	22		ns
toph	Output Ready Pulse HIGH	15	22		15	22		ns

<sup>\*</sup>This delay is dependent upon positive pulse width of SI input.

## **Functional Description**

#### **DATA INPUT**

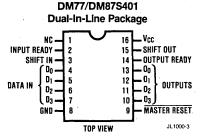
Data is entered in the FiFo on  $D_0$ - $D_3$  ( $D_0$ - $D_4$  on the 402) inputs. If the first location is ready to accept data, the Input Ready (IR) pin will be high. Data then present on the four input pins will be entered to the first location when the Shift In (SI) pin goes high. A high on the SI pin will cause the IR pin to go low. The old data will remain on the first location until SI is brought low again and IR goes low. If SI is brought low before IR goes low, data transfer will not take place until IR goes low. If the FiFo is not full (i.e., all locations contain data), IR will go high, indicating that the first location can accept more data from the four input pins. Simultaneously with IR going high, data will shift to the

second location and so forth until it either reaches the output stage or a full location. When the memory is full, IR will remain low and the FiFo will accept no more data.

#### **DATA TRANSFER**

Once data is entered into the second location, the transfer of any full location to the downstream adjacent empty location is automatically activated by an on-chip control. Thus data will stack up at the end of the FiFo while empty locations fill to the front. The time required for the first data to travel from input to output locations is called Data Throughput Time or t<sub>PT</sub>.

# **Connection Diagrams**



#### **Dual-In-Line Package** Vcc 18 INPUT READY SHIFT OUT 17 - OUTPUT READY SHIFT IN 16 Dn 15 **-** 01 D<sub>1</sub> 14 OUTPUTS 13 - 02 DATA IN $D_2$ **\_** 0<sub>3</sub> 12 D3 L D⊿ MASTER RESET 10 GND

**TOP VIEW** 

JL1000-4

DM77/DM87S402

Order Number DM77S401J, DM87S401J, DM77S402J, DM87S402J, DM77S401N, DM87S401N, DM77S402N or DM87S402N See NS Package J16A or N16A

<sup>\*\*</sup>These delays are dependent upon positive pulse width of SO input.

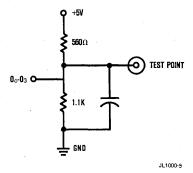
#### **DATA OUTPUT**

Data is output from Pins  $O_0$ - $O_3$  ( $O_0$ - $O_4$  on the 402). When data is shifted into the output stage, Output Ready (OR) goes high to indicate the presence of valid data. When the OR is high, data may be shifted out of  $O_0$ - $O_3$  by pulling Shift Out (SO) high. A high signal on the SO pin will cause the OR pin to go low. When the SO pin is brought low again, and OR is low, any valid data at the next upstream stage is shifted to the output. Then all valid upstream data moves down one location. New valid data on the output stage will again

cause OR to go high unless the output stage is empty (all data shifted out), in which case OR stays low.

Input Ready (IR) and Output Ready (OR) may also be used as status signals since IR will stay low for at least  $t_{\text{PT}}$  if the FiFo is full and OR will stay low for at least  $t_{\text{PT}}$  if the FiFo is empty.

#### Standard Test Load





# Bipolar and ECL RAMs PRELIMINARY

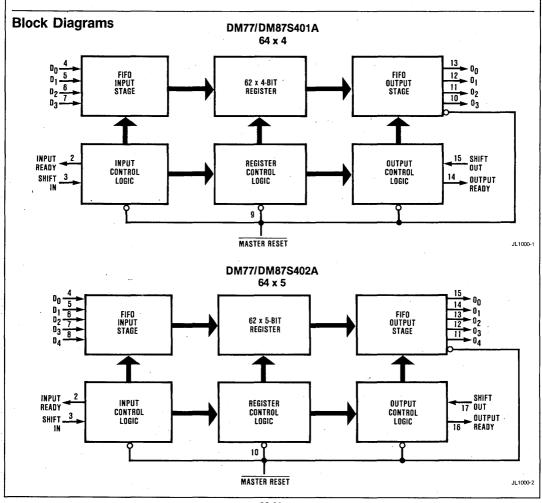
# DM77S401A/DM87S401A, DM77S402A/DM87S402A First-In, First-Out (FiFo) 64 × 4, 64 × 5 Serial Memories

## **General Description**

The DM77S401A is an expandable "fall-through" type high-speed First-in, First-out (FiFo) memory organized in 64-word by 4-bit, and 64-word by 5-bit structures respectively. A 15 MHz data rate allows usage in high-speed disc or tape controllers as well as PCM and communications buffer applications.

## **Features**

- 15 MHz shift in, shift out
- TTL inputs and outputs
- Inputs and outputs are symmetrically placed on package
- Easily expandable word and bit dimensions
- Either synchronous or asynchronous operation
- Fairchild F3341 MOS FiFo pin compatible but many times faster!
- Choice of 4-bit or 5-bit data width



## **Absolute Maximum Ratings**

Supply Voltage, Vcc 7 Volts
Input Voltage 7 Volts
Off-State Output Voltage 5.5 Volts
Storage Temperature -65° to +150° C

# Electrical Characteristics Over Operating Conditions DM77/DM87S401A, DM77/DM87S402A

Symbol	Parameter	Cond	Conditions		Тур	Max	Units
V <sub>IL</sub>	Low-Level Input Voltage					0.8	٧
V <sub>IH</sub>	High-Level Input Voltage			2			٧
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min,	I <sub>I</sub> = -18mA			-1.5	٧
I <sub>IL</sub>	Low-Level D <sub>0</sub> -D <sub>4</sub> , MR Input Current	V <sub>CC</sub> = Max,	V <sub>1</sub> = 0.45V			-0.4	mA
l <sub>IH</sub>	High-Level Input Current	V <sub>CC</sub> = Max,	V <sub>I</sub> = 2.4V			50	μА
կ	Maximum Input Current	V <sub>CC</sub> = Max,	V <sub>I</sub> = 5.5V			1.0	mA
V <sub>OL</sub>	Low-Level Output Voltage	$V_{CC} = Min$ $V_{IL} = 0.8V$ $V_{IH} = 2V$	I <sub>OL</sub> = 8mA		-	0.5	V
V <sub>OH</sub>	High-Level Output Voltage	$\begin{array}{c} V_{CC} = Min \\ V_{IL} = 0.8V \\ V_{IH} = 2V \end{array}$	I <sub>OH</sub> = -0.9mA	2.4			٧
los	Output Short-Circuit Current (Note 1)	V <sub>CC</sub> = Max,	V <sub>0</sub> = 0V	-20		-90	mA
Icc	Supply Current	V <sub>CC</sub> = Max Inputs Low, Outputs Open	DM77S401A DM87S401A DM77S402A DM87S402A			200 170 220 190	mA

# **Operating Conditions**

·		DN	177S401	A/402A	DN	187S401A	1/402A	
Symbol	Parameter	Min	Nom	Max	Min	Nom	Max	Units
V <sub>CC</sub>	Supply Voltage	4.5	5	5.5	4.75	5	5.25	٧
TA	Operating Free-Air Temperature (Note 2)	-55		+125	0		+75	°C
t <sub>SIH</sub>	Shift In HIGH Time	35	10		25	10		ns
t <sub>SIL</sub>	Shift In LOW Time	40	21		33	21		ns
t <sub>IDS</sub>	Input Data Setup	5	-9		0	-9		ns
t <sub>IDH</sub>	Input Data Hold Time	45	24		40	24		ns
t <sub>SOH</sub>	Shift Out HIGH Time	35	10		25	10		ns
tsoL	Shift Out LOW Time	35	10		25	10		ns
t <sub>MRW</sub>	Master Reset Pulse (Note 3)	30	10		20	10		ns
t <sub>MRS</sub>	Master Reset to SI	45	10		20	10		ns

Note 1: Not more than one output should be shorted at a time and duration of the short-circuit should not exceed one second.

Note 2: Case temperature.

Note 3: Master reset clears all the cells to the empty state, and the data outputs to a LOW state.

## **Switching Characteristics** Over Operating Conditions

		DM	77S401A	/402A	DM8			
Symbol	Parameter	Min	Ţyp	Max	Min	Тур	Max	Units
f <sub>IN</sub>	Shift In Rate	10	20		15	20		MHz
t <sub>IRL</sub>	Shift In to Input Ready LOW		25	50		25	40	ns
t <sub>IRH</sub> *	Shift In to Input Ready HIGH		30	50		30	42	ns
four	Shift Out Rate	10	20		15	20		MHz
torL	Shift Out to Output Ready LOW		32	65		32	45	ns
torn **	Shift Out to Output Ready HIGH		34	65		34	50	ns
t <sub>OD</sub> **	Output Data Delay		32	60		32	50	ns
t <sub>PT</sub>	Data Throughput or "Fall Through"		1.3	2.2		1.3	1.8	μS
t <sub>MRORL</sub>	Master Reset to OR LOW		26	65		26	60	ns
t <sub>MRIRH</sub>	Master Reset to IR HIGH		25	65		25	60	ns
t <sub>IPH</sub>	Input Ready Pulse HIGH	15	22		15	22		ns
toph	Output Ready Pulse HIGH	15	22		15	22		ns

<sup>\*</sup>This delay is dependent upon positive pulse width of SI input.

## **Functional Description**

#### **DATA INPUT**

Data is entered in the FiFo on  $D_0$ - $D_3$  ( $D_0$ - $D_4$  on the 402) inputs. If the first location is ready to accept data, the Input Ready (IR) pin will be high. Data then present on the four input pins will be entered to the first location when the Shift In (SI) pin goes high. A high on the SI pin will cause the IR pin to go low. The old data will remain on the first location until SI is brought low again and IR goes low. If SI is brought low before IR goes low, data transfer will not take place until IR goes low. If the FiFo is not full (i.e., all locations contain data), IR will go high, indicating that the first location can accept more data from the four input pins. Simultaneously with IR going high, data will shift to the

second location and so forth until it either reaches the output stage or a full location. When the memory is full, IR will remain low and the FiFo will accept no more data.

#### **DATA TRANSFER**

Once data is entered into the second location, the transfer of any full location to the downstream adjacent empty location is automatically activated by an on-chip control. Thus data will stack up at the end of the FiFo while empty locations fill to the front. The time required for the first data to travel from input to output locations is called Data Throughput Time or t<sub>PT</sub>.

#### **Connection Diagrams** DM77/DM87S402A **Dual-In-Line Package** DM77/DM87S401A **Dual-In-Line Package** Vcc INPUT READY . SHIFT OUT . Vcc SHIFT IN - OUTPUT READY INPUT READY 15 SHIFT OUT 16 00 SHIFT IN - OUTPUT READY 14 01 . Oo Dı 13 OUTPUTS Di **-** 0<sub>1</sub> 02 02 DATA IN 12 OUTPUTS DATA IN $D_2$ **-** 02 03 . 03 6 11 03 (DA L D3 10 GND MASTER RESET MASTER RESET TOP VIEW JI 1000-3 TOP VIEW JL1000-4 Order Number DM77S401AJ, DM87S401AJ, DM77S402AJ, DM87S402AJ, DM77S401AN,

DM87S401AN, DM77S402AN or DM87S402AN

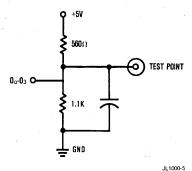
<sup>\*</sup>These delays are dependent upon positive pulse width of SO input.

Data is output from Pins  $O_0$ - $O_3$  ( $O_0$ - $O_4$  on the 402). When data is shifted into the output stage, Output Ready (OR) goes high to indicate the presence of valid data. When the OR is high, data may be shifted out of  $O_0$ - $O_3$  by pulling Shift Out (SO) high. A high signal on the SO pin will cause the OR pin to go low. When the SO pin is brought low again, and OR is low, any valid data at the next upstream stage is shifted to the output. Then all valid upstream data moves down one location. New valid data on the output stage will again

cause OR to go high unless the output stage is empty (all data shifted out), in which case OR stays low.

Input Ready (IR) and Output Ready (OR) may also be used as status signals since IR will stay low for at least  $t_{PT}$  if the FiFo is full and OR will stay low for at least  $t_{PT}$  if the FiFo is empty.

## Standard Test Load



# National Semiconductor

# **Bipolar and ECL RAMs**

# DM75S68/DM85S68 16 × 4 Edge Triggered Registers

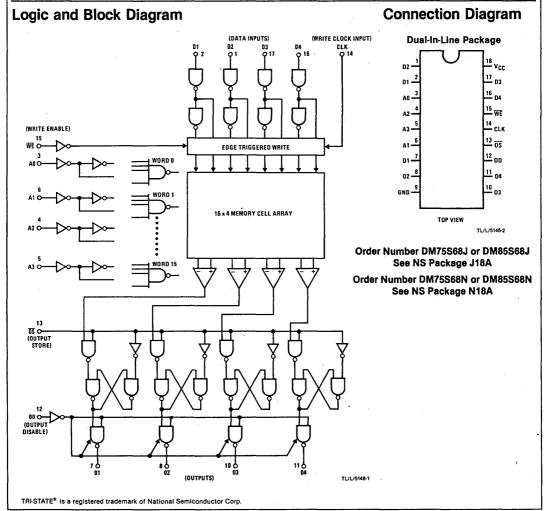
# **General Description**

These Schottky memories are addressable "D" register files. Any of its 16 four-bit words may be asynchronously read or may be written into on the next clock transition. An input terminal is provided to enable or disable the synchronous writing of the input data into the location specified by the address terminals. An output disable terminal operates only as a TRI-STATE® output control terminal. The addressable register data may be latched at the outputs and retained as long as the output store terminal is held in a low state. This memory storage condition is independent of the state of the output disable terminal.

All input terminals are high impedance at all times, and all outputs have low impedance active drive logic states and the high impedance TRI-STATE condition.

## **Features**

- On-chip output register
- PNP inputs reduce input loading
- Edge triggered write
- High speed—30 ns typ
- All parameters guaranteed over temperature
- **TRI-STATE output**
- Schottky-clamped for high speed
- Optimized for register stack applications
- Typical power dissipation—350 mW



<b>Absolute Maximum Ratin</b>	gs (Note 1)	Operating Conditions							
			Min	Max	Units				
Supply Voltage	7.0V	Supply Voltage, V <sub>CC</sub>							
Input Voltage	5.5V	DM85S68	4.75	5.25	٧				
Output Voltage	5.5V	DM75S68	4.5	5.5	V				
Storage Temperature Range Lead Temperature (Soldering, 10 secon	-65°C to +150°C ds) 300°C	Temperature, T <sub>A</sub> DM85S68 DM75S68	0 55	70 + 125	°C				

## **Electrical Characteristics**

over recommended operating free-air temperature range unless otherwise noted (Notes 2 and 3)

	Parameter		Conditions		Mìn	Тур	Max	Units
V <sub>IH</sub>	High Level Input Voltage				2			٧
VIL	Low Level Input Voltage						0.8	٧
V <sub>OH</sub>	High Level Output Voltage	V <sub>CC</sub> = Min	I <sub>OH</sub> = - 2.0 m	nA, DM75S68	2.4			٧
		ACC = 141111	$I_{OH} = -5.2 \text{ m}$	nA, DM85S68	2.4			٧
V <sub>OL</sub>	Low Level Output Voltage	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	40 4	DM75S68			0.5	٧
	·	V <sub>CC</sub> = Min, I	OL = 16 MA	DM85S68			0.45	V
I <sub>IH</sub>	High Level Input Current	V <sub>CC</sub> = Max,	Clock Input				50	μA
	<u> </u>	V <sub>IH</sub> = 2.4V	All Others				25	μА
ĺ	High Level Input Current at Maximum Voltage	V <sub>CC</sub> = Max,	V <sub>IH</sub> = 5.5V				1.0	mA
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max,	Clock Input				- 500	μА
		V <sub>IL</sub> = 0.5V	All Others				- 250	μΑ
los	Short Circuit Output Current (4)	$V_{CC} = Max,$	V <sub>OL</sub> = 0V		- 20		- 55	mA
Icc	Supply Current	V <sub>CC</sub> = Max				70	100	mA
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18 mA				- 1.2	٧.	
loz	TRI-STATE Output Current		$V_0 = 2.4V$				+ 40	μА
		$V_{CC} = Max$ $V_{O} = 0.5V$					- 40	μΑ

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The table of "Electrical Characteristics" provides conditions for actual device operation.

Note 2: Unless otherwise specified min/max limits apply across the  $-55^{\circ}$ C to  $+125^{\circ}$ C temperature range for the DM75S68 and across the  $0^{\circ}$ C to  $+70^{\circ}$  C range for the DM85S68. All typicals are given for  $V_{CC} = 5.0V$  and  $T_{A} = 25^{\circ}$ C.

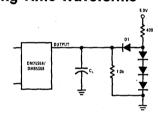
Note 3: All currents into device pins shown as positive, out of device pins as negative, all voltages referenced to ground unless otherwise noted. All values shown as max or min on absolute value basis.

Note 4: Only one output at a time should be shorted.

# Switching Characteristics over recommended operating range of TA and VCC unless otherwise noted

Parameter			}	DM75S68			DM85S68			
	raiametei			Тур	Max	Min	Тур	Max	Units	
tzH	Output Enable	e to High Level		20	40		20	35	ns	
tżL	Output Enable	e to Low Level		14	30		14	24	ns	
t <sub>HZ</sub>	Output Disabl	e Time from High Level		10	18		10	15	ns	
t <sub>LZ</sub>	Output Disabl	e Time from Low Level		12	22		12	18	ns	
t <sub>AA</sub>	Access Time	Address to Output		30	55		30	40	ns	
tosa		Output Store to Output		20	35		20	30	ns	
t <sub>CA</sub>		Clock to Output		25	50		25	40	ns	
t <sub>ASC</sub>	Set-Up Time	Address to Clock	25	5		15	5		ns	
tosc		Data to Clock	15	5		5	0		ns	
tASOS		Address to Output Store	40	15		30	15		ns	
twesc	•	Write Enable Set-Up Time	10	5		5	0		ns	
tossc		Store Before Write	15	0		10	0		ns	
tAHC	Hold Time	Address from Clock	15	5		10	5		ns	
tDHC		Data from Clock	20	5		15	5		ns	
tAHOS		Address from Output Store	10	0		5	. 0		ns	
twehc		Write Enable Hold Time	20	5		15	5		ns	

# **AC Test Circuit and Switching Time Waveforms**



 $C_L = 5.0 \text{ pF for } t_{HZ}, t_{LZ}$ 

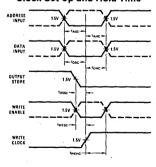
 $C_L = 30 \text{ pF for all others}$ 

C<sub>L</sub> includes probe and Jig capacitance

All diodes are 1N3064

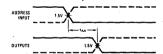
#### Write Cycle

#### Clock Set-Up and Hold Time

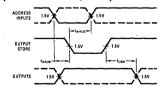


#### Read Cycle

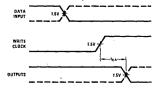
#### **Address to Output Access Time**



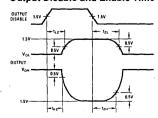
### Output Store Access, Set-Up and Hold Time



#### **Clock to Output Access**



### **Output Disable and Enable Time**



Note: Input waveforms supplied by pulse generator having the following characteristics: V = 3.0V,  $t_R \le 2.5$  ns, PRR  $\le 1.0$  MHz and  $Z_{OUT} = 50M$ .



# **Bipolar and ECL RAMs**

# IDM29705/29705A 16-Word by 4-Bit Two-Port RAM/Register File

## **General Description**

The IDM29705 and IDM29705A are 16-word by 4-bit RAM/Register File chips housed in a standard 28-pin dual-in-line package. The IDM29705 and the IDM29705A feature TRI-STATE® outputs. These RAMs, which are fabricated using SCL® (Schottky ECL Technology) feature two separate output ports that enable any two 4-bit words to be read from these outputs simultaneously. Each output port contains a four-bit latch. A common Latch Enable (LE) input is used to control all eight latches. The device, which has two Write Enable (WE) inputs, is designed so that either Write Enable (WE) or 2) and Latch Enable (LE) inputs can be wired together to make the operation of the RAM appear edge-triggered.

The device, which has fully decoded A-address and B-address fields, can address any of the 16 memory words for the A-output port and, simultaneously, select any of the 16 words for presentation at the B-output port. Incoming data is written into the fourbit RAM word selected by the B-address. The D inputs are used to load the new data into the device.

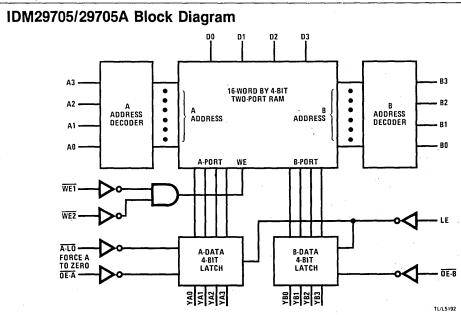
Several of these devices can be cascaded to increase the total number of memory words in the system. When  $\overline{\text{OE-A}}$  is high, the A-output port is in the high-impedance mode.  $\overline{\text{OE-B}}$ , when high, forces the B-output port to the high-impedance state.

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The writing of new data into the RAM is controlled by the Write Enable inputs. With both Write Enable inputs low, data is written into the word selected by the B-address field. The memory outputs follow the data inputs during writing if the Latch Enable (LE) is high. With either Write Enable high, no data is written into the RAM.

### **Features and Benefits**

- 16-Word by 4-Bit, 2-Port RAM/Register Files
- Two Output Ports, Each with Separate Output Control
- 4-Bit Latches on Each Output Port
- Non-Inverted Data Output with Respect to Data Input
- Output Enable and Write Enable Inputs Provide Ease in Cascading
- SCL Technology (Schottky ECL) Provides ECL Speeds While Keeping Low Power Schottky Input/ Output Voltage and Power Consumption Compatibility
- 100% Reliability Testing in Compliance with MIL-STD-883



# **Absolute Maximum Ratings**

Storage Temperature -65°C to +150°C Temperature (Ambient) Under Bias -55°C to +125°C Supply Voltage to Ground Potential -0.5V to +6.3VDC Voltage Applied to Outputs for - 0.5V to + V<sub>CC</sub> max **High Output State** 

DC Input Voltage -0.5V to +5.5VDC Output Current, into Outputs

30mA **DC Input Current** -30mA to +5.0mA

# **Operating Range**

	Ambient	
P/N	Temperature	v <sub>cc</sub>
IDM29705JC	0°C to +70°C	4.75V to 5.25V
IDM29705JM, JM/883	-55°C to +125°C	4.50V to 5.50V
IDM29705AJC, NC	0°C to +70°C	4.75V to 5.25V
IDM29705AJM, JM/883	-55°C to +125°C	4.50V to 5.50V

## Standard Screening (conforms to MIL-STD-883 for Class C parts)

	MIL-STD-883		Lev	vei
Step	Method	Conditions	DC, PC	DM, FM
Pre-Seal Visual Inspection	2010	В	100%	100%
Stabilization Bake	1008	C: 24-hour 150 °C	100%	100%
Temperature Cycle	1010	C: -65°C to +150°C 10 cycles	100%	100%
Centrifuge	2001	B: 10,000 G	100%	100%
Fine Leak	1014	A: 5×10 <sup>-8</sup> atm-cc/cm <sup>3</sup>	100%	100%
Gross Leak	1014	C2: Fluorocarbon	100%	100%
Electrical Test Subgroups 1 and 7 and 9	5004	See below for definitions of subgroups	100%	100%
Insert Additional Screening Here for C	lass B Parts		1 10 10	
Group A Sample Tests Subgroup 1 Subgroup 2 Subgroup 3 Subgroup 7 Subgroup 8 Subgroup 9	5005	See below for definitions of subgroups	LTPD = 5 LTPD = 7 LTPD = 7 LTPD = 7 LTPD = 7 LTPD = 7	LTPD = 5 LTPD = 7 LTPD = 7 LTPD = 5 LTPD = 7 LTPD = 5 LTPD = 5

# **Additional Screening for Class B Parts**

	MIL-STD-883		Level
Step	Method	Conditions	DMB, FMB
Burn-In	1015	D: 125°C, 160 hours min	100%
Electrical Test	5004		
Subgroup 1		-	100%
Subgroup 2			100%
Subgroup 3			100%
Subgroup 7			100%
Subgroup 9	1		100%

# **Group A Subgroups**

(as defined in MIL-STD-883, method 5005)

Subgroup	Parameter	Temperature
1 ,	DC	25°C
. 2	DC	Maximum rated temperature
3	DC	Minimum rated temperature
7	Function	25°C
8	Function	Maximum and minimum rated temperature
9	Switching	25 °C
10	Switching	Maximum rated temperature
11	Switching	Minimum rated temperature

Symbol	Parameter	Test C	ondition	s (Note 1)	Min.	Typ (Note 2)	Max.	Units
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> = min			2.4			3/-14-
	(IDM29705 only)	$V_{IN} = V_{IH} \text{ or } V_{IL}$	Com'l	, I <sub>OH</sub> = -4.0mA	2.4	Ţ		Volts
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> = min					0.4	
		$V_{IN} = V_{IH} \text{ or } V_{IL}$	I <sub>OL</sub> =	8.0mA			0.45	
	•		I <sub>OL</sub> =	12mA			0.5	Volts
			loL =	16mA (Note 4)			0.5	
V <sub>IH</sub>	Input HIGH Level	Guaranteed input inputs	Guaranteed input logical HIGH voltage for all inputs		2.0			Volts
V <sub>IL</sub>	Input LOW Level	Guaranteed input inputs	Guaranteed input logical LOW voltage for all inputs				8.0	Volts
VI	Input Clamp Voltage	V <sub>CC</sub> = min, I <sub>IN</sub> =	– 18mA				- 1.5	Volts
I <sub>IL</sub>	Input LOW Current	V <sub>CC</sub> = max, V <sub>IN</sub> :	= 0.4V	A <sub>i</sub> , B <sub>i</sub>			- 0.25	mA
				Others			- 0.36	mA
I <sub>IH</sub>	Input HIGH Current	V <sub>CC</sub> = max, V <sub>IN</sub> :	= 2.7V				20	μΑ
l <sub>i</sub>	Input HIGH Current	V <sub>CC</sub> = max, V <sub>IN</sub> :	= 5.5V				0.1	mA
loz	Off State (High Impedance) Output Current	$V_{CC} = max$ $V_{IN} = V_{IH} \text{ or } V_{IL}$	00				20 - 20	μΑ
Isc	Output Short Circuit Current	V <sub>CC</sub> = max 29705A		- 30		- 85	mA	
	(Note 3)	29705		-25	ļ	-85		
Icc	Power Supply Current	V <sub>CC</sub> = max				120	175	mA
				5.25V, T = 70°C			155	mA
		MLA	$V_{CC} = $	5.5V, T = 125°C			145	mA ·

Note 1: For conditions shown as Min. or Max., use the appropriate value specified under Electrical Characteristics for the applicable device type.

Note 2: Typical limits are at  $V_{CC} = 5.0 V$ , 25°C ambient and maximum loading.

Note 3: Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.

Note 4: 29705A commercial temperature range only.

**Switching Characteristics** (Input Levels = 0 V and 3.0 V, Transitions measured at 1.5 V) Combinational Delays (in nanoseconds) ( $C_L = 50 \text{ pF}$ )

			Cor	Comm'l		Ail	
				Max. (Note 1)		Max. (Note 2)	
Parameters	From	То	Conditions	705	705A	705	705A
Assess Time	A Address Stable	YA Stable	LE UICH	40	30	55	35
Access Time B Address Stal		YB Stable LE = HIGH		40	30	55	35
	Both WE LOW	YA = D	LE = HIGH, A = B	45	45	48	45
	BOTH WE LOW	YB = D	LE = HIGH	45	45	48	45
Turn-On Time	OE-A or OE-B LOW			25	20	. 25	25
Turn-Off Time	OE-A or OE-B HIGH	YA or YB Off	C <sub>L</sub> = 5pF (Note 3)	. 20	20	20	20
Reset Time	A-LO LOW	YA LOW		20	20	30	25
Enable Time	LE HIGH	YA and YB Stable		25	20	25	25
	Data In	YA or YB = D	LE = HIGH, WE both LOW, A = B	45	45	45	45

# Switching Characteristics (Cont'd) Minimum Setup and Hold Times (In nanoseconds)

				Con	nm'l	· N	lil
			•		ax. le 1)		ax. te 2)
Parameters	From	То	Conditions	705	705A	705	705A
Data Setup Time	D Stable	Either WE HIGH		20	15	25	20
Data Hold Time	Either WE HIGH	D Changing		0	0	0	0
Address Setup Time	B Stable	Both WE LOW		3.	0	5	3
Address Hold Time	Either WE HIGH	B Changing		0	0	0	0
Latch Close	LE LOW	WE <sub>1</sub> LOW	WE <sub>2</sub> LOW	0	0	0	0
Before Write Begins	LE LOW	WE <sub>2</sub> LOW	WE <sub>1</sub> LOW	0	0	0	0
Address Setup Before Latch Closes	A or B Stable	LE LOW		20	15	40	20

### Minimum Pulse Widths (in nanoseconds)

•				Cor	nm'l	N	iil
					ax. te 1)		ax. te 2)
Parameters	From	То	Conditions	705	705A	705	705A
Write Pulse Width	WE <sub>1</sub>	HIGH-LOW-HIGH	WE <sub>2</sub> LOW	25	20	25	20
	WE <sub>2</sub>	HIGH-LOW-HIGH	WE1 LOW	20	20	20	20
A Latch Reset Pulse	A-LO	HIGH-LOW-HIGH		20	15	20	15
Latch Data Capture	LE	LOW-HIGH-LOW	Address Stable	20	15	20	15

Note 1:  $T_A = 0$ °C to +70°C,  $V_{CC} = 5.0V \pm 5\%$ .

Note 2: -55°C to +125°C,  $V_{CC} = 5.0 V \pm 10\%$ 

Note 3: Measured from 1.5V at the input to 0.5V change in the output level.

## **Function Tables**

#### Write Control

			RAM Outputs a	at Latch Inputs
WE <sub>1</sub>	WE <sub>2</sub>	Function	A-Port	B-Port
L	L	Write D into B	A data (A ≠ B)	D input data
Χ.	н	No write	A data	B data
н	χ	No write	A data	B data

#### YA Read

Inputs				
0E-A	A-LO	LE	YA Output	Function
Н	·X	Х	Z	High impedance
L	L	X	L ·	Force YA LOW
L	н	н	A-Port RAM data	Latches transparent
L	Н	L.	NC NC	Latches retain data

## **Function Tables (continued)**

#### YB Read

Inpu	Inputs		
OE-B	LE	YB Output	Function
Н	Х	Ζ ,	. High impedance
L	Н	B-Port RAM data	Latches transparent
L	L	NC	Latches retain data

H = HIGH

Z = High impedance NC = No change

L = LOW X = Don't care

# Pinout Descriptions of the IDM29705/29705A

D<sub>3</sub>-D<sub>0</sub>: Through these inputs new data can be written in the location specified by the B-address inputs.

A<sub>3</sub>-A<sub>6</sub>: The 4-bit address presented at the A inputs selects one of the 16 memory words for presentation at the A-data latch outputs.

**B**<sub>3</sub>- **B**<sub>0</sub>: The 4-bit address presented at the B inputs selects one of the 16 memory words for presentation at the B-data latch outputs. This address also selects the location into which data is written.

YA3-YA0: The four A-data latch outputs.

YB3-YB0: The four B-data latch outputs.

WE<sub>1</sub>, WE<sub>2</sub>: Write enable inputs. When both are low, enables data to be written into the RAM location selected by the B-address field. When either Write Enable input is high, no data can be written into memory.

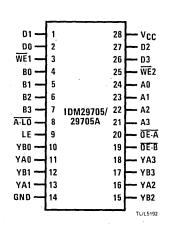
**OE-A:** A-port output enable. When low, data in the A-data latch is present at the YA<sub>i</sub> outputs. When high, the YA<sub>i</sub> outputs are in the high-impedance mode.

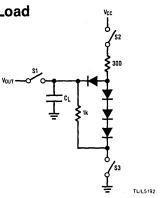
OE-B: B-port output enable. When low, data in the B-data latch is presented at the YB<sub>i</sub> outputs. When high, the YB<sub>i</sub> outputs are in the high-impedance mode.

LE: Latch enable. The LE input acts as control for both the RAM-A and RAM-B output ports. When high the latches are transparent and data from the RAM, as selected by the A and B address inputs, is presented at the outputs. When low, the latches retain the last data read from the RAM regardless of the current A and B address inputs.

A-LO: Force A to zero. This input operates to force the A-port latch outputs low independent of the LE input or A address inputs. The A-output bus can be forced low using this control input. With A-LO high, the A latches operate in their normal manner. Once forced low, the A latches remain low independent of the A-LO input if the Latch Enable (LE) is low.

# IDM29705/29705A Connection Diagram and Test Load





Note 1: C<sub>L</sub> = 50 pF includes scope probe, wiring and stray capacitances without device in test fixture.

Note 2: S1, S2, S3 are closed during function tests and all AC tests except output enable tests.

Note 3: S1 and S3 are closed while S2 is open for  $t_{PZH}$  test. S1 and S2 are closed while S3 is open for  $t_{PZL}$  test. Note 4:  $C_L$  = 5 pF for output disable tests.

# National Semiconductor

# **Bipolar and ECL RAMs**

# DM10414, DM10414A 256 × 1 ECL Random Access Memory

## **General Description**

The DM10414, DM10414A is a 256-word by 1-bit ECL random access memory. The fully static memory is designed with active low chip selects and separate I/O pins. The 8 address bits (A0 through A7) are fully decoded on the chip. Applications such as scratch pad, cache, and buffer memories are ideal for this high speed RAM.

An unterminated emitter-follower output is provided to allow the outputs to be wire-ORed. Separate Data In and non-inverted Data Out pins are provided. These RAMs are compatible with compensated and uncompensated 10k ECL families.

### **Features**

- Fully compatible with standard and voltage compensated 10k series ECL
- Temperature range

0°C to +75°C

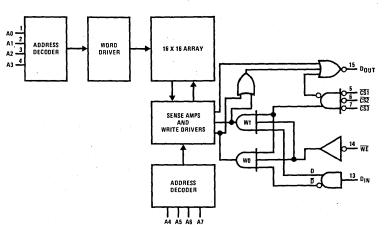
- Unterminated emitter-follower output for wire-ORing
- Power dissipation decreases with increasing temperature
- Typical address access

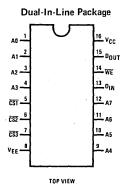
DM10414	1	0 ns
DM10414A		7 ns

■ Typical chip select access

DM10414 DM10414A 4 ns 3 ns

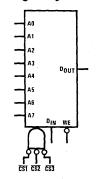
# **Block and Connection Diagrams**





Order Number DM10414J or DM10414AJ See NS Package J16A

# Logic Symbol



#### Pin Names

A0A7	Address Inputs
DIN	Data Input
DOUT	Data Output
CS1, CS2, CS3	Chip Select Inputs
WE	Write Enable

## **Truth Table**

Ì	cs	WE	DIN	DOUT	MODE
	H	х	Х	L	Not Selected
	L	L	н	L.	Write 1
	L	L	L	L	Write 0
	Ł	Н	×	DOUT	Read

L = low (-1.7V nominal)

H = high (-0.9V nominal)

X = don't care

## **Absolute Maximum Ratings**

-55°C to +125°C

Supply Voltage (VEE) Ambient Temperature (TA)

**Operating Conditions** 

MIN -5.46

MAX -4.94 +75

UNITS °C

Temperature Under Bias (Ambient) Storage Temperature Range -65°C to +150°C VEE Relative to VCC -7.0V to +0.5V Any Input Relative to VCC VEE to +0.5V Output Current (Output High) -30 mA to +0.1 mA Lead Temperature (Soldering, 10 seconds)

## **DC Electrical Characteristics**

VEE = -5.2V, Output Load =  $50\Omega$  and 30 pF to -2.0V,  $T_A = 0$ °C to +75°C (Notes 1–4)

SYMBOL	PARAMETER	CONDITIONS	TA	B LIMIT	LIMIT	UNIT
Vон	Output Voltage High	VIN = VIHA or VILB				
	1		l o°c	-1000	-840	mV
•			+25°C	-960	-810	ļ
		·	+75°C	-900	-720	
VOL	Output Voltage Low	VIN = VIHA or VILB			ĺ	
			0°C	-1870	-1665	mV
	1		+25°C	-1850	-1650	
			+75°C	-1830	-1625	
VOHC	Output Voltage High	VIN = VIHB or VILA	1		İ	
	1	Performed on one input	0°C	-1020		mV
	, [	at a time	+25°C	-980		
<u> </u>	,		+75°C	-920		
VOLC	Output Voltage Low	VIN = VIHB or VILA		1	ļ	
		Performed on one input	0°C	]	-1645	mV
		at a time	+25°C		-1630	
			+75°C		-1605	<u> </u>
VIH	Input Voltage High	Guaranteed Input Voltage High for All Inputs				
			0°C	-1145	-840	mV
			+25°C	_1105	-810	
			+75°C	-1045	-720	
VIL	Input Voltage Low	Guaranteed Input Voltage Low for All Inputs				
	. i	•	0°C	-1870	-1490	mV
	1		+25°C	-1850	-1475	
			+75°C	-1830	-1450	
ЧН	Input Current High	VIN = VIHA				
		Performed on one input	. 0°C		1	
		at a time	to	1	220	μΑ
			+75°C	<u> </u>		ļ ·
HL	Input Current Low, CS	VIN = VILB	0°C			1
	1	Performed on one input	to	0.5	170	μΑ
	All Others	at a time	+75°C	-50		<u> </u>
IEE	Power Supply Current	All Inputs and Outputs Open	0°C			
	(Pin 8) (Note 5)		to		ĺ	
			+75°C	-150	1	mA

Note 1: Conditions for testing not shown in the tables are chosen to guarantee operation under "worst case" conditions.

Note 2: The specified limits represent the "worst case" value for the parameter. Since these "worst case" values normally occur at the temperature extremes, additional noise immunity and guard banding can be achieved by decreasing the allowable system operating ranges.

Note 3: Guaranteed with transverse air flow exceeding 400 linear F.P.M. and 2-minute warm-up period. Typical resistance values of the package are: θ<sub>JA</sub>, (Junction to Ambient) = 90°C/W (still air); θ<sub>JA</sub> (Junction to Ambient) = 50°C/W (at 400 F.P.M. air flow); θ<sub>JC</sub> (Juction to Case) = 25° C/W.

Note 4: "A" indicates the most positive value, "B" indicates the most negative value.

Note 5: Typical values at  $V_{EE} = -5.2V$ :  $T_A = 0^{\circ}C$ ,  $I_{EE} = -105$  mA;  $T_A = 75^{\circ}C$ ,  $I_{EE} = -90$  mA.

## **Functional Description**

Addressing the DM10414, DM10414A is achieved by means of the 8 address lines A0–A7. Each of the  $2^8$  one-zero combinations of the address lines corresponds to a bit location in the memory. The active low Chip Selects together with the unterminated emitter-follower output allows for wire-ORing. A  $50\Omega$  resistor to -2V (or an equivalent network) is required to provide a low at the output when the device is off. This termination is required for both single device or wire-ORed operation.

The device is selected with  $\overline{CS}$  low and deselected with  $\overline{CS}$  high. The operating mode is controlled by the active low Write Enable ( $\overline{WE}$ ).  $\overline{WE}$  low causes the data at the Data Input (DIN) to be stored at the selected address.  $\overline{WE}$  low also causes the output to be disabled (low due to the  $50\Omega$  pull-down resistor).  $\overline{WE}$  high causes the data stored at the selected address to be present at the Data Out (DOUT) pin.

### **AC Electrical Characteristics**

 $V_{EE}$  = -5.2V ±5%, Output Load = 50 $\Omega$ , 30 pF to -2.0V,  $T_A$  = 0°C to 75°C, 400 LFM

				DM10414A		DM10414			
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP (NOTE 6)	MAX	MIN	TYP (NOTE 6)	MAX	UNITS
READ MODE									
tACS	Chip Select Access			3	5		4	7	ns
	Time	Measured Between				1			
tRCS	Chip Select Recovery Time	50% Points (Note 7)		3	5		4	7	ns
tAA	Address Access Time		Ì	7	10		10	15	ns
WRITE MOD	E								
tw	Write Pulse Width (to Guarantee Writing)		6	3.5		8	5		ns
twsp	Data Set-Up Time Prior to Write		2	0		2	0		ns
tWHD	Data Hold Time After Write	Measured Between 50% Points	2	0		2	0		ns
tWSA	Address Set-Up Time Prior to Write		3	0		4	0		ns
AHW	Address Hold Time After Write		2	0		3	1		ns
twscs	Chip Select Set-Up Time Prior to Write		2	0		2	0	!	ns
tWHCS	Chip Select Hold Time After Write		2	. 0		2	0		ns
tWS	Write Disable Time			3	5		4	7	ns
₩R	Write Recovery Time	1	1	3	5	]	4	7	ns
RISE TIME	AND FALL TIME	·				·	•		<u> </u>
tr	Output Rise Time	Measured Between	T	3	<u> </u>		4		ns
tf	Output Fall Time	50% Points	1	3	l	1	4		ns

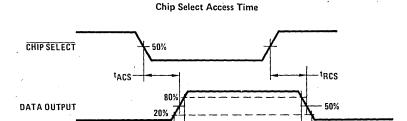
## Capacitance

			DM10414A				DM10414		
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP (NOTE 6)	MAX .	MIN	TYP (NOTE 6)	MAX	UNITS
C <sub>IN</sub> C <sub>OUT</sub>	Input Pin Capacitance Output Pin Capacitance	Measure With a Pulse Technique		4 7	5 8		4 7	5 8	pF pF

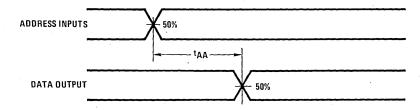
Note 6: Typical values are at  $V_{EE} = -5.2V$ ,  $T_A = 25^{\circ}C$  and maximum loading.

Note 7: The maximum address access time is guaranteed to be the worst case bit in the memory using a pseudorandom testing pattern.

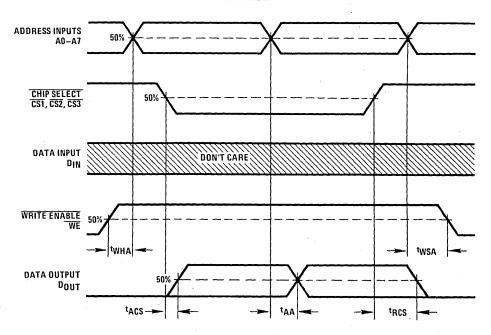
# **Switching Time Waveforms**



#### Address Access Time

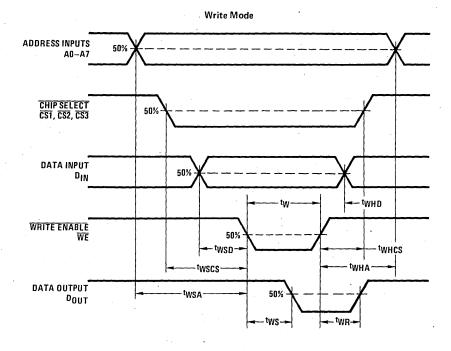


#### Read Mode



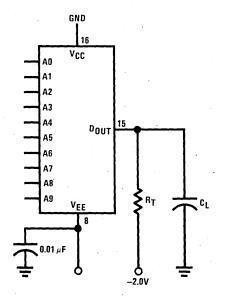
22

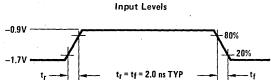
# Switching Time Waveforms (Continued)



## **Test Conditions**

**Loading Conditions** 





All timing measurements referenced to 50% of input levels C  $_L$  = 30 pF including jig and stray capacitance  $R_T$  =  $50\Omega$ 



# **Bipolar and ECL RAMs**

# DM10415, DM10415A 1024 × 1 ECL Random Access Memory

## **General Description**

The DM10415, DM10415A is a 1024-word by 1-bit ECL random access memory. This fully static memory is designed with an active low chip select and separate I/O pins. The 10 address bits (A0 through A9) are fully decoded on the chip. Applications such as scratch pad, cache, and buffer memories are ideal for this high speed RAM.

An unterminated emitter-follower output is provided to allow the outputs to be wire-ORed. Separate Data In and non-inverted Data Out pins are provided. These RAMs are compatible with compensated and uncompensated 10k ECL families.

#### **Features**

- Fully compatible with standard and voltage compensated 10k series ECL
- Temperature range

 $0^{\circ}$ C to  $+75^{\circ}$ C

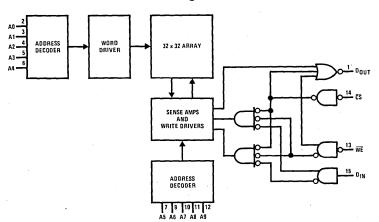
- Unterminated emitter-follower output for wire-ORing
- Power dissipation decreases with increasing temperature
- Typical address access

DM10415	25 ns
DM10415A	12 ns

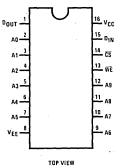
Typical chip select access

DM10415 DM10415A 7 ns 4 ns

## **Block and Connection Diagrams**

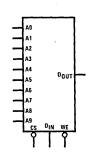


#### **Dual-In-Line Package**



Order Number DM10415J or DM10415AJ See NS Package J16A

# **Logic Symbol**



#### Pin Names

A0-A9	Address Inputs
DIN	Data Input
DOUT	Data Output
CS	Chip Select
WE	Write Enable

## **Truth Table**

CS	WE	DIN	DOUT	MODE
• н	Х	х	L	Not Selected
L	L	H	L	Write 1
[ L '	L	L	L	Write 0
L	н	×	DOUT	Read

L = low (-1.7V nominal)

H = high (-0.9V nominal)

X = don't care

## **Absolute Maximum Ratings**

**Operating Conditions** 

Temperature Under Bias (Ambient)  $-55^{\circ}$ C to  $+125^{\circ}$ C Storage Temperature Range  $-65^{\circ}$ C to  $+150^{\circ}$ C V<sub>EE</sub> Relative to V<sub>CC</sub> -7.0V to +0.5V Any Input Relative to V<sub>CC</sub>  $V_{\rm EE}$  to +0.5V Output Current (Output High) -30 mA to +0.1 mA Lead Temperature (Soldering, 10 seconds)  $300^{\circ}$ C

## **DC Electrical Characteristics**

VEE = -5.2V, Output Load =  $50\Omega$  and 30 pF to -2.0V,  $T_A = 0$ °C to +75°C (Notes 1 -4)

SYMBOL	PARAMETER	CONDITIONS		B LIMIT	A LIMIT	UNITS
Voн	Output Voltage High	VIN = VIHA or VILB				
			0°C	-1000	-840	mV
		•	+25°C	-960	-810	
			+75°C	-900	-720	
VOL	Output Voltage Low	VIN = VIHA or VILB				
			0°C	-1870	-1665	mV
	•		+25°C	-1850	-1650	
			+75°C	-1830	-1625	
Vонс	Output Voltage High	VIN = VIHB or VILA				
			0°C	-1020		mV
			+25°C .	-980		
			+75°C	-920		
Volc	Output Voltage Low	VIN = VIHB or VILA				
	,		0°C		-1645	mV
		•	+25°C	·	-1630	1
			+75°C		-1605	
VIH	Input Voltage High	Guaranteed Input Voltage High				
	,	for All Inputs	ļ			
			0°C	-1145	-840	mV
			+25°C	-1105	-810	
			+75°C	-1045	<del>−</del> 720	
VIL	Input Voltage Low	Guaranteed Input Voltage Low	٠,			
		for All Inputs		1		
			0°C	-1870	-1490	mV
*		·	+25°C	~1850	-1475	
			+75°C	-1830	-1450	
Ιн	Input Current High	VIN=VIHA		i ·	1	
		·	0°C			
			to		220	μΑ
			+75°C	<u></u>		
HL	Input Current Low, CS	VIN = VILB	0°C		ľ	
			to	0.5	170	μÀ
	All Others		+75°C	-50		
IEE	Power Supply Current	All Inputs and Outputs Open	0°C			
	(Pin 8) (Note 5)		to			
	1 .	1	+75°C	-150	Į	mA ·

Note 1: Conditions for testing not shown in the tables are chosen to guarantee operation under "worst case" conditions.

Note 2: The specified limits represent the "worst case" value for the parameter. Since these "worst case" values normally occur at the temperature extremes, additional noise immunity and guard banding can be achieved by decreasing the allowable system operating ranges.

Note 3: Guaranteed with transverse air flow exceeding 400 linear F.P.M. and 2-minute warm-up period. Typical resistance values of the package are:  $\theta_{JA}$ , (Junction to Ambient) =  $90^{\circ}$  C/W (still air);  $\theta_{JA}$  (Junction to Ambient) =  $50^{\circ}$  C/W (at 400 F.P.M. air flow);  $\theta_{JC}$  (Juction to Case) =  $25^{\circ}$  C/W.

Note 4: "A" indicates the most positive value, "B" indicates the most negative value.

Note 5: Typical values at  $V_{EE} = -5.2V$ :  $T_A = 0^{\circ}C$ ,  $I_{EE} = -105$  mA;  $T_A = 75^{\circ}C$ ,  $I_{EE} = -90$  mA.

## **Functional Description**

Addressing the DM10415/DM10415A is achieved by means of the 10 address lines A0–A9. Each of the  $2^{10}$  one-zero combinations of the address lines corresponds to a bit\_location in the memory. The active low Chip Select  $\overline{(CS)}$  together with the unterminated emitter-follower output allows for memory array expansion to 2048 words without additional decoding. This emitter-follower output allows for wire-ORing. A  $50\Omega$  resistor to -2V (or an equivalent network) is required to provide a low at the output when the device is off. This termination is required for both single device or wire-ORed operation.

The device is selected with  $\overline{CS}$  low and deselected with  $\overline{CS}$  high. The operating mode is controlled by the active low Write Enable ( $\overline{WE}$ ).  $\overline{WE}$  low causes the data at the Data Input ( $D_{IN}$ ) to be stored at the selected address.  $\overline{WE}$  low also causes the output to be disabled (low due to the 50 $\Omega$  pull-down resistor).  $\overline{WE}$  high causes the data stored at the selected address to be present at the Data Out ( $D_{OUT}$ ) pin.

## **AC Electrical Characteristics**

 $V_{EE} = -5.2V$ ,  $\pm 5\%$ , Output Load =  $50\Omega$ , 30 pF to -2.0V,  $T_A = 0^{\circ}C$  to  $+75^{\circ}C$ , 400 LFM

			1	DM10415A			DM10415	}	
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP (NOTE 6)	MAX	MIN	TYP (NOTE 6)	MAX	UNITS
READ MOD	E								
tACS	Chip Select Access Time	Measured at 50% of		4	8		7	10	ns
tRCS	Chip Select Recovery Time	Input to Valid Output (Note 7)		4	8		7	10	ns
tAA	Address Access Time			12	20		25	35	ns
WRITE MOD	DE .	<del></del>	<u> </u>	<del></del>	<b></b>	<del></del>	<u> </u>	······	
tw	Write Pulse Width (to Guarantee Writing)								
	DM10415A DM10415	twsA = 8 ns twsA = 20 ns	12	10		. 25	20		ns
tWSD	Data Set-Up Time Prior to Write		4	0		5	0		ns
tWHD	Data Hold Time After Write		4	0		5	0		ns
tWSA	Address Set-Up Time Prior to Write								
	DM10415A DM10415	t <sub>W</sub> = 12 ns t <sub>W</sub> = 25 ns	5	3		8	5		ns
tWHA	Address Hold Time After Write		3	0		4	1		ns
twscs	Chip Select Set-Up Time Prior to Write		4	0		5	0		ns
tWHCS	Chip Select Hold Time After Write		4	0		5	0	!	ns
tws	Write Disable Time			4	10	·	7	10	ns
twr	Write Recovery Time			4	10		7	10	ns
RISE TIME	AND FALL TIME								
tr	Output Rise Time	Measured Between 20%		5			5		n:
tf	Output Fall Time	and 80% Points	1	5		ł	5		n:

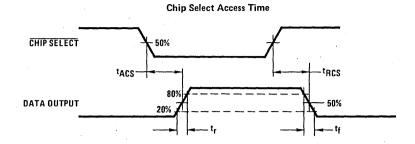
Capacitance

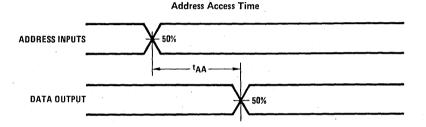
			DM10415A				DM10415		
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP (NOTE 6)	мах	MIN	TYP (NOTE 6)	MAX	UNITS
C <sub>IN</sub> C <sub>OUT</sub>	Input Pin Capacitance Output Pin Capacitance	Measure With a Pulse Technique		7	5 8		7	5 8	pF pF

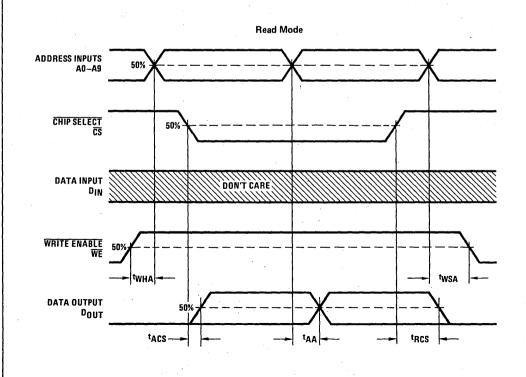
Note 6: Typical values are at  $V_{EE} = -5.2V$ ,  $T_A = 25^{\circ}$  C and maximum loading.

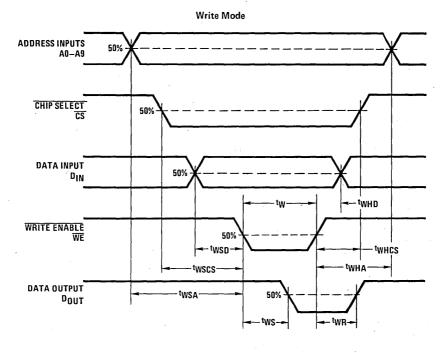
Note 7: The maximum address access time is guaranteed to be the worst case bit in the memory using a pseudorandom testing pattern.

# **Switching Time Waveforms**



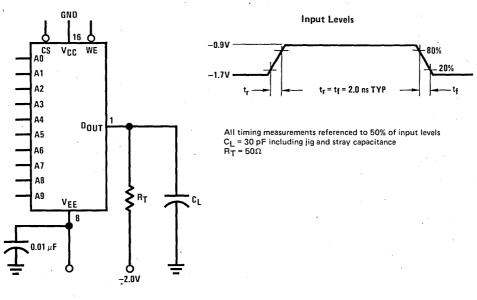






## **Test Conditions**





# Bipolar and ECL RAMs PRELIMINARY

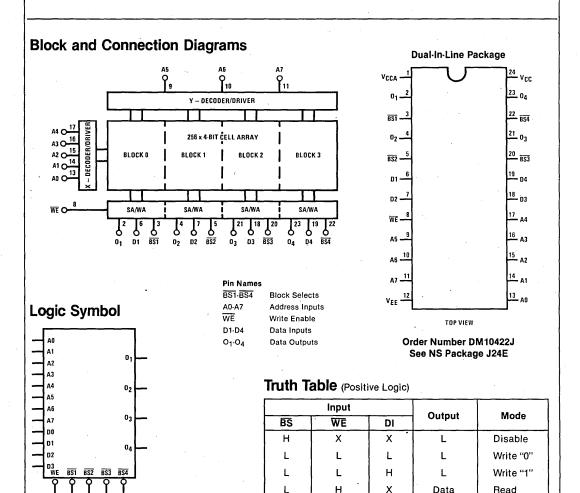
# DM10422 1024-Bit (256 × 4) ECL RAM

# **General Description**

The DM10422 is normally a 256-word by 4-bit random access memory. However the memory has four Block Select (BS0-BS3) inputs which allow wire-ORing of any of the four blocks for a maximum 1024-word by 1-bit memory. The high speed access time allows its use in scratch pad, buffer, and control storage applications. The device is voltage compensated and is compatible with all 10k logic. Separate Data In and Data Out pins allow the set up of data for a write cycle while performing a read.

## **Features**

- 4 separate Block Select inputs for configurations from 256 × 4 to 1024 × 1
- Maximum address access time—12 ns
- Typical Block Select access time—3.5 ns
- 10k logic compatible



# **Absolute Maximum Ratings**

# DC Electrical Characteristics $V_{EE} = -5.2V$ , $R_L = 50\Omega$ to -2.0V, $T_A = 0$ °C to +75°C, air flow exceeding 500 LFM

Symbol	Parameter	Conditions		Min	Тур	Max	Units
V <sub>OH</sub>	Output Voltage		0°C	- 1000		- 840	
			25°C	- 960		- 810	
		V <sub>IN</sub> = V <sub>IHA</sub>	75°C	- 900		- 720	mV
VoL		or V <sub>ILB</sub>	0°C	- 1870		- 1665	1110
			25°C	- 1850		- 1650	
			75°C	- 1830		- 1625	
V <sub>OHC</sub>	Output Threshold Voltage		0°C	- 1020			
			25°C	- 980			mV
		$V_{IN} = V_{IHB}$	75°C	- 920			
V <sub>OLC</sub>		or V <sub>ILA</sub>	0°C			- 1645	
	j		25°C			- 1630	
		[ · _ · _ ·	75°C			- 1605	
V <sub>IH</sub>	Input Voltage	Guaranteed Input Voltage	0℃	- 1145		- 840	
	]	High for All Inputs	25°C	1105		- 810	
			75°C	- 1045		- 720	mV
V <sub>IL</sub>		Guaranteed Input Voltage	0°C	- 1870		- 1490	IIIV
'-		Low for All Inputs	25°C	- 1850		- 1475	
			75°C	- 1830		- 1450	`
I <sub>IH</sub>	Input Current	$V_{IN} = V_{IHA}$	0°C to 75°C			220	i
I <sub>IL</sub>	1	BS , ,	000 4- 7500	0.5		170	μΑ
·-		Other V <sub>IN</sub> = V <sub>ILB</sub>	0°C to 75°C	- 50			
I <sub>EE</sub>	Supply Current	All Inputs and Outputs	0°C	- 200	- 160		mA
		Open, Test Pin 12	75°C		- 145		IIIA

## **AC Electrical Characteristics**

 $V_{EE} = -5.2V \pm 5\%$ ,  $R_L = 50\Omega$  to -2.0V,  $T_A = 0$ °C to +75°C, air flow exceeding 500 LFM

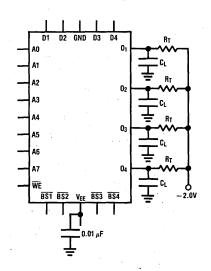
Symbol	Parameter	Conditions	Min	Тур	Max	Units
READ MOD	E					
t <sub>ABS</sub>	Block Select Access Time				5.0	ns
t <sub>RBS</sub>	Block Select Recovery Time				5.0	ns
t <sub>AA</sub>	Address Access Time				12	ns
WRITE MOD	DE .					
t <sub>W</sub>	Write Pulse Width	$t_{WSA} = 3 \text{ ns}$	7			ns
t <sub>WSD</sub>	Data Set-Up Time	1	2.0			ns
t <sub>WHD</sub>	Data Hold Time		2.0			ns
t <sub>WSA</sub>	Address Set-Up Time	t <sub>W</sub> = 7 ns	3.0			ns
t <sub>WHA</sub>	Address Hold Time		2.0			ns
t <sub>WSBS</sub>	Block Select Set-Up Time		2.0			ns
t <sub>WHBS</sub>	Block Select Hold Time		2.0			ns
t <sub>WS</sub>	Write Disable Time				5	ns
t <sub>WR</sub>	Write Recovery Time				. 7	ns

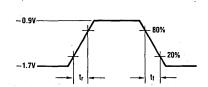
## **Electrical Characteristics** (Continued)

 $V_{EE} = -5.2V \pm 5\%$ ,  $R_L = 50\Omega$  to -2.0V,  $T_A = 0$ °C to +75°C, air flow exceeding 500 LFM

Symbol	Parameter	Conditions	Min	Тур	Max	Units
RISE/FALL	TIME					
t <sub>r</sub>	Output Rise Time			3		ns
t <sub>f</sub>	Output Fall Time			3		ns
CAPACITAN	ICE					
C <sub>IN</sub>	Input Capacitance			4		pF
C <sub>OUT</sub>	Output Capacitance			7		pF

# **Test Circuit and Input Waveform**





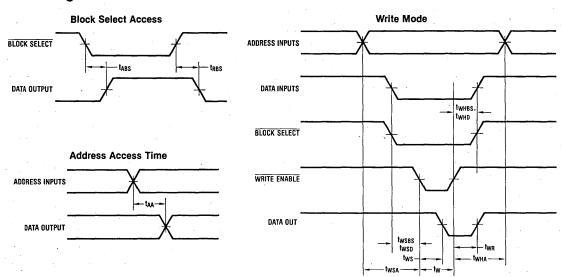
 $t_f = t_f = 2.0 \text{ ns} \pm 10\%$ 

R<sub>T</sub> = 50Ω

C<sub>L</sub> = 30 pF

All timing measurements are referenced from 50% of input levels to 50% of input/output levels.

# **Switching Time Waveforms**



# Bipolar and ECL RAMs PRELIMINARY

# DM10422A 1024-Bit (256 × 4) ECL RAM

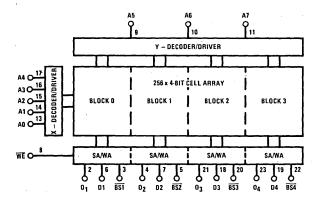
# **General Description**

The DM10422A is normally a 256-word by 4-bit random access memory. However the memory has four Block Select (BS0-BS3) inputs which allow wire-ORing of any of the four blocks for a maximum 1024-word by 1-bit memory. The high speed access time allows its use in scratch pad, buffer, and control storage applications. The device is voltage compensated and is compatible with all 10k logic. Separate Data In and Data Out pins allow the set up of data for a write cycle while performing a read.

## **Features**

- 4 separate Block Select inputs for configurations from 256 × 4 to 1024 × 1
- Maximum address access time -- 10 ns
- Typical Block Select access time-3.5 ns
- 10k logic compatible

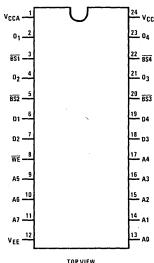
## **Block and Connection Diagrams**



#### Pin Names

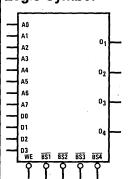
BS1-BS4	Block Selects
A0-A7	Address Input
WE	Write Enable
D1-D4	Data Inputs
01-04	Data Outputs

#### Dual-In-Line Package



### Order Number DM10422AJ See NS Package J24E

# **Logic Symbol**



## Truth Table (Positive Logic)

		Input		0	11-4-	
BS	WE	DI	Output	Mode		
	Н	Х	X	L	Disable	
1	L	L	. L	L	Write "0"	
	L	L	H	L	Write "1"	
ł	L	н	Х	Data	Read	

# **Absolute Maximum Ratings**

 $\begin{array}{lll} Supply \ Voltage, V_{EE} \ to \ V_{CC} & +0.5 \ V \ to -7.0 V \\ Input \ Voltage, V_{IN} & +0.5 \ V \ to \ V_{EE} \\ Output \ Current & -30 \ mA \\ Storage \ Temperature, T_{stg} & -65 \ ^{\circ}C \ to +150 \ ^{\circ}C \\ Storage \ Temperature \ Under \ Bias, T_{stg} \ (Bias) & -55 \ ^{\circ}C \ to +125 \ ^{\circ}C \end{array}$ 

# DC Electrical Characteristics $V_{EE} = -5.2V$ , $R_{L} = 50\Omega$ to -2.0V, $T_{A} = 0$ °C to +75°C, air flow exceeding 500 LFM

Symbol	Parameter	Conditions		Min	Тур	Max	Units
V <sub>OH</sub>	Output Voltage		0°C	- 1000		- 840	
			25°C	- 960		- 810	1
	·	$V_{IN} = V_{IHA}$	75°C	- 900		- 720	m∨
V <sub>OL</sub>		or V <sub>ILB</sub>	0°C	- 1870		- 1665	l IIIv
			25°C	- 1850		- 1650	
			75°C	- 1830		- 1625	1
V <sub>OHC</sub>	Output Threshold Voltage		0°C	- 1020			
			25°C	- 980			]
		$V_{IN} = V_{IHB}$	75°C	- 920			
V <sub>OLC</sub>		or V <sub>ILA</sub>	0°C			- 1645	mV
0_0	-		25°C			- 1630	1630
			75°C			- 1605	1
V <sub>iH</sub>	Input Voltage	Guaranteed Input Voltage	0°C	-1145		- 840	
		High for All Inputs	25°C	- 1105		- 810	
	± .		75°C	- 1045		- 720	
V <sub>IL</sub>	, '	Guaranteed Input Voltage	0°C	- 1870		- 1490	mV
· <del>-</del>		Low for All Inputs	25°C	- 1850		- 1475	
	·		75°C	- 1830		- 1450	]
l <sub>IH</sub>	Input Current	$V_{IN} = V_{IHA}$	0°C to 75°C			220	
IIL		BS ,, ,,	0°C to 75°C	0.5		170	μΑ
		Other V <sub>IN</sub> = V <sub>ILB</sub>	0 0 10 75 0	- 50			
I <sub>EE</sub>	Supply Current	All Inputs and Outputs	0°C	- 200	- 160		mA
		Open, Test Pin 12	75°C		<u> </u>		IIIA

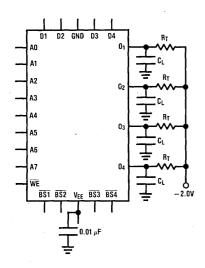
# AC Electrical Characteristics $V_{EE} = -5.2V$ , $R_L = 50\Omega$ to -2.0V, $T_A = 0$ °C to +75 °C, air flow exceeding 500 LFM

Symbol	Parameter	Conditions	Min	Тур	Max	Units
READ MODE	E					
t <sub>ABS</sub>	Block Select Access Time			4	5.0	ns
t <sub>RBS</sub>	Block Select Recovery Time			4	5.0	ns
t <sub>AA</sub>	Address Access Time			8	10	ns
WRITE MOD	E					
t <sub>W</sub>	Write Pulse Width	t <sub>WSA</sub> = 2 ns	6	4		ns
t <sub>WSD</sub>	Data Set-Up Time	·	2.0			ns
t <sub>WHD</sub>	Data Hold Time		2.0		, , , , , , , , , , , , , , , , , , , ,	ns
t <sub>WSA</sub>	Address Set-Up Time	t <sub>W</sub> =6 ns	2.0			ns
t <sub>WHA</sub>	Address Hold Time	:	2.0			ns
twsss	Block Select Set-Up Time		2.0		,	ns
t <sub>WHBS</sub>	Block Select Hold Time	]	2.0			ns
t <sub>WS</sub>	Write Disable Time	1			5	ns
t <sub>WR</sub>	Write Recovery Time	] .			7	ns

**Electrical Characteristics** (Continued)  $V_{EE} = -5.2V$ ,  $R_L = 50\Omega$  to -2.0V,  $T_A = 0^{\circ}C$  to  $+75^{\circ}C$ , air flow exceeding 500 LFM

Symbol	Parameter	Conditions	Min	Тур	Max	Units
RISE/FALL T	IME					
t <sub>r</sub>	Output Rise Time			3		. ns
t <sub>f</sub>	Output Fall Time			3		ns
CAPACITAN	CE					
C <sub>IN</sub>	Input Capacitance			4		pF
C <sub>IN</sub>	Output Capacitance			7		pF

## **Test Circuit and Input Waveform**





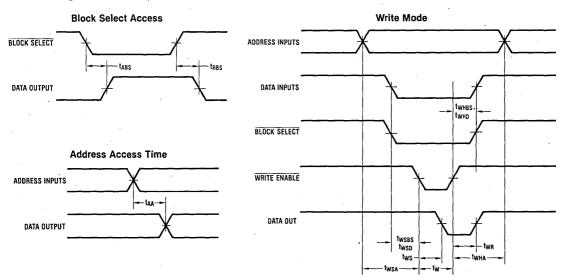
 $t_r = t_f = 2.0 \text{ ns} \pm 10\%$ 

 $R_T = 50\Omega$ 

C<sub>L</sub> = 30 pF

All timing measurements are referenced from 50% of input levels to 50% of input/output levels.

### **Switching Time Waveforms**





## **Bipolar and ECL RAMs**

## DM10470 Standard, DM10470A High Speed, **DM10470L Low Power** 4096-Bit ( $4096 \times 1$ ) ECL RAMs

### **General Description**

The DM10470 is a 4096-bit random access memory organized 4096-words by 1 bit. It is designed for high speed scratch pad and buffer storage applications. It is voltage and temperature compensated and compatible with all 10k logic. It has separate Data In and Data Out pins. The active low Chip Select CS and unterminated emitter-follower outputs allow easy expansion.

The DM10470 is speed and power selected to provide costperformance benefits not available from any other manufacturer.

#### Features

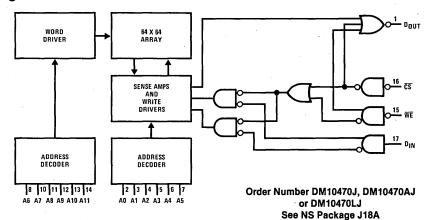
Three speed-power combinations for maximum costperformance:

Standard DM10470 High speed DM10470A Low power DM10470L

25 ns/200 mA max 15 ns/200 mA max 25 ns/130 mA max

- 10k logic compatible
- Unterminated emitter-follower outputs

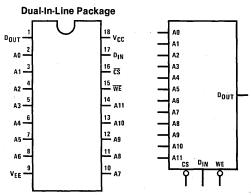
### **Logic Diagram**



### **Connection Diagram**

TOP VIEW

## **Logic Symbol**



### Truth Table

	Inputs		Output	Mode
CS	WE	D <sub>IN</sub>	Open Emitter	lilloud .
Н	X	Х	L	Not Selected
L	L	L	L	Write "0"
L	L	н	L	Write "1"
L	Н	X	D <sub>OUT</sub>	Read

#### Pin Names

<del>cs</del>	Chip Select Inpu
A0-A11	Address Inputs
WE	Write Enable
DIN .	Data Input
DOLLT	Data Output

#### **Operating Conditions Absolute Maximum Ratings** Max Units Temperature Under Bias (Ambient) - 55°C to + 125°C Supply Voltage (VFF) ٧ - 5.46 - 4.94 -65°C to +150°C Storage Temperature Range Ambient Temperature (TA) °C +75V<sub>EE</sub> Relative to V<sub>CC</sub> -7.0V to +0.5VAny Input Relative to V<sub>CC</sub> $V_{EE}$ to $\pm 0.5V$

#### **DC Electrical Characteristics**

Lead Temperature (Soldering, 10 seconds)

Output Current (Output High)

 $V_{EE} = -5.2V$ , output load = 50 $\Omega$  and 30 pF to -2.0V,  $T_A = 0$ °C to +75°C (Notes 1, 2, 3 and 4)

-30 mA to + 0.1 mA

300°C

Symbol	Parameter	Conditions	TA	B Limit	A Limit	Units
V <sub>OH</sub>	Output Voltage High	$V_{IN} = V_{IHA}$ or $V_{ILB}$	0°C + 25°C + 75°C	1000 960 900	-840 -810 -720	mV
V <sub>OL</sub>	Output Voltage Low	$V_{IN} = V_{IHA}$ or $V_{ILB}$	0°C + 25°C + 75°C	1870 1850 1830	1665 1650 1625	mV
V <sub>OHC</sub>			0°C + 25°C + 75°C	- 1020 - 980 - 920		mV
V <sub>OLC</sub>	Output Voltage Low	$V_{IN} = V_{IHB}$ or $V_{ILA}$	0°C + 25°C + 75°C		- 1645 - 1630 - 1605	mV
V <sub>IH</sub>	Input Voltage High	Guaranteed Input Voltage High for All Inputs	0°C + 25°C + 75°C	- 1145 - 1105 1045	- 840 810 720	mV
V <sub>IL</sub>	V <sub>IL</sub> Input Voltage Low Guaranteed Input Voltage Low for All Inputs		0°C + 25°C + 75°C	1870 1850 1830	- 1490 - 1475 - 1450	mV
I <sub>IH</sub>	Input Current High	$V_{IN} = V_{IHA}$	0°C to +75°C		220	μΑ
I <sub>IL</sub>	Input Current Low, CS All Others	$V_{IN} = V_{ILB}$	0°C to +75°C	0.5 50	170	μ <b>A</b>

Note 1: Conditions for testing not shown in the tables are chosen to guarantee operation under worst-case conditions.

Note 2: The specified limits represent the worst-case value for the parameter. Since these worst-case values normally occur at the temperature extremes, additional noise immunity and guard banding can be achieved by decreasing the allowable system operating ranges.

Note 3: Guaranteed with transverse air flow exceeding 500 linear FPM and 2-minute warm-up period. Typical resistance values of the package are:  $\theta_{JA}$ , (junction to ambient) = 90°C/W (still air);  $\theta_{JC}$  (junction to case) = 25°C/W.

Note 4: "A" indicates the most positive value, "B" indicates the most negative value.

#### **AC Electrical Characteristics**

 $V_{EE} = -5.2V \pm 5\%$ , output load = 50 $\Omega$ , 30 pF to -2.0V,  $T_A = 0$ °C to +75°C

		•		DM10470	\		DM10470			DM10470L		
Symbol	Parameter	Conditions	Min	Typ (Note 6)	Max	Min	Typ (Note 6)	Max	Min	Typ (Note 6)	Max	Units
READ N	/IODE											
tacs	Chip Select Access Time			4	8		5	10		5	10	ns
t <sub>RCS</sub>	Chip Select Recovery Time	Measured at 50% of Input to 50% of Output (Note 7)		4	8		5	10	) )	5	10	ns
taa	Address Access Time			12	15		18	25	}	18	25	ns
WRITE	MODE						·			•	<b></b> -	<u> </u>
tw	Write Pulse Width (to Guarantee Writing) DM10470A DM10470/L	$t_{WSA} = 3 \text{ ns}$ $t_{WSA} = 6 \text{ ns}$	10		;	15			15			ns
t <sub>WSD</sub>	Data Set-Up Time Prior to Write		2	1		2	1	}	2	1		ns
t <sub>WHD</sub>	Data Hold Time After Write		, 2	0		2	0		. 2	0		ns
twsa	Address Set-Up Time Prior to Write DM10470A DM10470/L	t <sub>W</sub> = 10 ns t <sub>W</sub> = 15 ns	3	1		3	1		3	1		ns
t <sub>WHA</sub>	Address Hold Time After Write		2	0		2	0		2	0		ns
twscs	Chip Select Set-Up Time Prior to Write		2	1		2	1		2	1		ns
t <sub>wHCS</sub>	Chip Select Hold Time After Write	.*	. 2	0		2	0		2	0.		ns
tws	Write Disable Time	50% of Input to 50% of Output		5	8		5			5	8	ns
t <sub>WR</sub>	Write Recovery Time	50% of input to 50% of Output		5	8	<u> </u>	5		<u> </u>	5	8	ns
RISE TI	ME AND FALL TIME											
t <sub>r</sub>	Output Rise Time	Measured Between 20%		3			3			3 .		ns
tf	Output Fall Time	and 80% Points		3			3	L_		3		ns

### Capacitance

-				DM10470A			DM10470			DM10470L			
	Symbol	Parameter	Conditions	Min	Typ (Note 6)	Max	Min	Typ (Note 6)	Max	Min	Typ (Note 6)	Max	Units
_	C <sub>IN</sub>	Input Pin Capacitance	Measure with a Pulse		4	5		4	5		4	5	pF
	C <sub>OUT</sub>	Output Pin Capacitance	Technique		7	8		7	8		7	8	pF

## Power Supply Current $V_{EE} = -5.2V$ , output load = $50\Omega$ and 30 pF to -2.0V

Symbol	Parameter	Conditions	DM10470A B Limit	DM10470 B Limit	DM10470L B Limit	Units
I <sub>EE</sub>	Power Supply Current (Pin 8) (Note 5)	All Inputs and Outputs Open, T <sub>A</sub> = 25°C	<b>– 200</b>	- 200	<b>– 130</b>	mA

Note 5: Typical values at  $V_{EE} = -5.2V$ ;  $T_A = 0$ °C,  $I_{EE} = -145$  mA;  $T_A = 25$ °C,  $I_{EE} = 135$  mA;  $T_A = 75$ °C,  $I_{EE} = 125$  mA.

Note 6: Typical values are at  $V_{EE} = -5.2V$ ,  $T_A = 25$ °C and maximum loading.

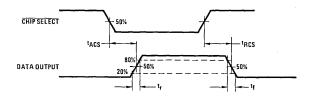
Note 7: The maximum address access time is guaranteed to be the worst-case bit in the memory using a pseudorandom testing pattern.

Addressing the DM10470/DM10470A is achieved by means of the 12 address lines, A0-A11. Each of the  $2^{12}$  one-zero combinations of the address lines corresponds to a unique bit location in the memory. The memory array can be expanded to 8192 words without additional decoding, by using the active low Chip Select ( $\overline{CS}$ ) and wire-ORing the unterminated emitter-follower outputs. A 50 $\Omega$  resistor -2V (or an equivalent network) is required to provide a low at the output when the device is off. This termination is required for both single device or wire-ORed operation.

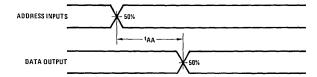
The device is selected with  $\overline{CS}$  low and deselected with  $\overline{CS}$  high. The operating mode is controlled by the active low Write Enable ( $\overline{WE}$ ).  $\overline{WE}$  low causes the data at the Data Input (D<sub>IN</sub>) to be stored at the selected address.  $\overline{WE}$  low also causes the output to be disabled (low due to the 500 pull-down resistor).  $\overline{WE}$  high causes the data stored at the selected address to be present at the Data Output (D<sub>OUT</sub>) pin when  $\overline{CS}$  is low.

### **Switching Time Waveforms**

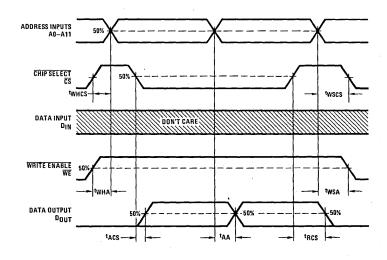
#### **Chip Select Access Time**



#### Address Access Time



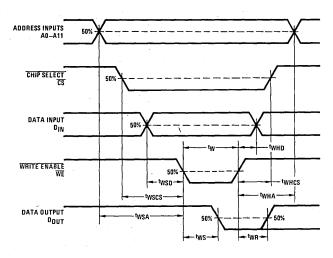
#### Read Mode



**22**.

## Switching Time Waveforms (Continued)

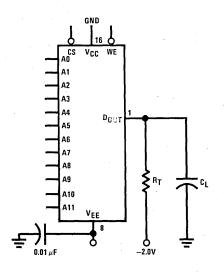
#### Write Mode

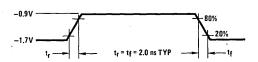


### **Test Conditions**

#### **Loading Conditions**

#### input Levels





All timing measurements referenced to 50% of input levels  $C_L=30$  pF including jig and stray capacitance  $R_T=50\Omega$ 



# Bipolar and ECL RAMs

### DM10474/DM10474A (1024 x 4) 4096-Bit, 10k ECL RAM

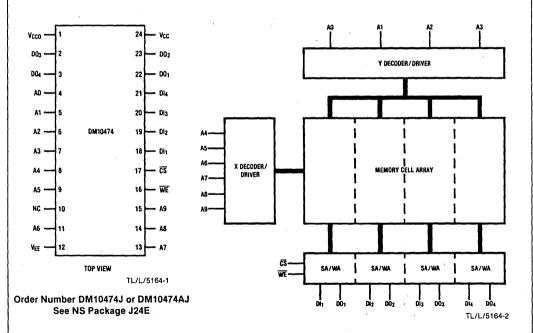
#### **General Description**

The DM10474 is a 4096-bit read/write random access memory, organized in the popular 1024 words by 4-bit configuration. The input and output levels are voltage compensated 10k ECL levels. The DM10474A has a maximum access time of 15 ns, and the DM10474 has a maximum access time of 25 ns.

#### **Features**

- 1024 words x 4-bit organization
- On chip voltage compensation for improved noise margin
- Fully compatible with industry standard 10k series ECL families
- Address access time: 25 ns max for standard part, 15 ns max for "A" part.
- Chip select access time: 10 ns max for standard part, 6 ns max for "A" part.
- Low power dissipation: -220 mA max for "A" part, -200 mA max for standard.
- Pin compatible with F10474 and MBM10474

### **Connection and Block Diagrams**



#### **Truth Table**

	Inputs		Output	Mode
ĊS	WE	D <sub>IN</sub>	Open Emitter	iii.ouc
Н	х	Х	L	Not Selected
L	L	L	L	WRITE "0"
L	L	н	L	WRITE"1"
L	Н	Х	Dout	READ

H = high voltage level

L = low voltage level

X = don't care

### **DC Electrical Characteristics**

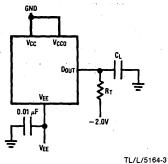
( $V_{CC}$  = 0V,  $V_{EE}$  = -5.2V, output load =  $50\Omega$  to -2.0V and airflow  $\geq 500$  LFM unless otherwise noted.)

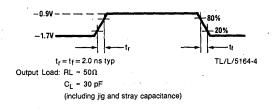
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
VoH	Output High Voltage	0°C	-1000		-840	
	(V <sub>IN</sub> = V <sub>IH max</sub> or V <sub>IL min</sub> )	25°C	-970	1	-810	−mV
		75°C	-900		-720	
V <sub>OL</sub>	Output Low Voltage	0°C	-1870		-1665	
	$(V_{IN} = V_{IH \max} \text{ or } V_{IL \min})$	25°C	-1850		-1650	m∨
		75°C	-1830		-1625	
V <sub>OHC</sub>	Output High Voltage	0°C	-1020			
	$(V_{IN} = V_{IH \min} \text{ or } V_{IL \max})$	25°C	-980		,	m∨
		75°C	-920			
V <sub>OLC</sub>	Output Low Voltage	0°C			-1645	
	(V <sub>IN</sub> = V <sub>IH min</sub> or V <sub>IL max</sub> )	25°C	1		- 1630	m\
**		75°C			~1605	
V <sub>IH</sub>	Input High Voltage	0°C	-1145		-840	
	(Guaranteed Input Voltage High for All Inputs)	25°C	-1105	İ	-810	m∨
		75°C	-1045		-720	
VIL	Input Low Voltage	. 0°C	-1870		-1490	
	(Guaranteed Input Voltage Low for All Inputs)	25°C	-1850		1475	m∨
		75°C	-1830		<b>−1450</b> .	
I <sub>tH</sub>	Input High Current (V <sub>IN</sub> = V <sub>IH max</sub> )	0° to 75°C			220	μΑ
I <sub>IL</sub>	Input Low Current (V <sub>IN</sub> = V <sub>IL min</sub> )	0° to 75°C	-50			μΑ
հլ_	CS Input Low Current (V <sub>IN</sub> = V <sub>IL min</sub> )	0° to 75°C	. 0.5		170	μΑ
IEE	Power Supply Current	0° to 75°C				
	(All Inputs and Outputs Open)		-200			m/
			-220*	1	{	1

<sup>\*</sup>For the DM10474A,

### **AC Test Circuit and Switching Time Waveform**

(Full guaranteed operating ranges, output load =  $50\Omega$  to -2.0V and 30 pF to GND and airflow  $\geq 500$  LFM unless otherwise noted.)

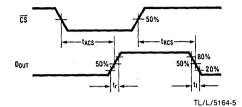


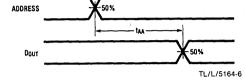


Note: All timing measurements referenced to 50% input levels.

Symbol	Parameter	DM1	0474	DM10	Units	
		Тур	Max	Тур	Max	Units
t <sub>AA</sub>	Address Access Time		25		15	ns
tacs	Chip Select Access Time		10		. 6	ns
t <sub>RCS</sub>	Chip Select Recovery Time	10		6		ns

## **Read Cycle Timing Diagrams**

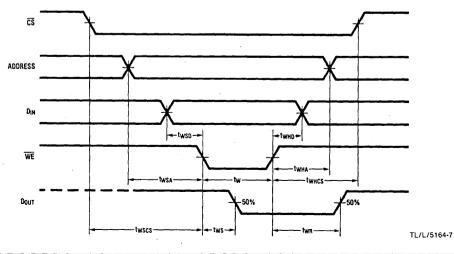




**Write Cycle** 

Cumbal	Parameter	ļ	DM10474			DM10474A	١,	Units
Symbol		Min	Тур	Max	Min	Тур	Max	Units
t <sub>W</sub>	Write Pulse Width			12			8	ns
tws	Write Disable Time		4					ns
t <sub>WR</sub>	Write Recovery Time		4					ns
twsa	Address Set Up Time		0					ns
twscs	Chip Select Set Up Time		0					ns
t <sub>WSD</sub>	Data Set Up Time		0					ns
t <sub>WHA</sub>	Address Hold Time		0					ns
twncs	Chip Select Hold Time		0					ns
t <sub>WHD</sub>	Data Hold Time		0					ns

## **Write Cycle Timing Diagrams**



22

Rice	T:			T:
RICE	ııme	ann	-all	IIMA

Symbol	Dovernator	DM10474/DM10474A		IA .	Unita
	Parameter	Min	Тур	Max	Units
t <sub>r</sub>	Output Rise Time	_	2.5	_	ns
t <sub>f</sub>	Output Fall Time	_	2.5		ns



# Section 23 2900 Family/ Bipolar Microprocessor



DEVICE	DESCRIPTION	PAGE NUMBER
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IDM2909A/11A	Microprogram Sequencer	23-24
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IDM29803	16-Way Branch Controller	23-51
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' '	Byte Swapping	23-76
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	Using the IDM2909A/11A in a Computer Control Unit	23-78
	Speed Enhancement of Bipolar Bit-Slice Microprocessor Systems	23-86
AN-203	Bit Slice Microprocessor Design Takes a Giant Step Forward with "Schottky-Coupled-Logic" Circuits	23-93
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AN-230	Fine Tuning the ALU Carry Path	23-112





## Introduction

Since its introduction in 1976, the 2900 Family of Bipolar Microprocessor Components has rapidly established itself as the industry standard for bitmicroprogrammable system National Semiconductor is pleased to have contributed to the success of this family by providing the highest performance components available from any manufacturer. We are firmly committed to continuing this emphasis on performance, since we feel that designers of bipolar systems will continue to demand increased component speed as their system throughput requirements increase. We are not only dedicated to providing components, but also to developing the design techniques that optimize their use in systems. This is evidenced by the expanded Applications section in this book.

To achieve this higher performance, National developed a design technique referred to as SCL1 and introduced its first 2900 Family product-the IDM2901A-in 1977. This device featured AC characteristics that were 25% faster than anything on the market at that time. In 1978, a speed-selected version of the 2901A-the IDM2901A-1—was introduced. This device further improved performance by an additional 15%. In 1982 an additional 30% performance improvement was provided by the IDM2901A-2, a device that combines the SCL design technique with the latest advances in bipolar LSI processing. All of this has been accomplished without a single compromise with regard to functionality or DC characteristics. In fact, power dissipation in all cases is equal to or less than that of the competing Low Power Schottky devices.

Following its success with the IDM2901, National applied the SCL design technique to the IDM2909A, IDM2910A, IDM2911A, and IDM29705A. These devices also have speed characteristics that are 30%-50% better than those of the competing LS versions.

Not content to simply second source existing 2900 functions, National has also added to the family additional devices that were found to be significantly useful in bit-slice microprocessor design. These include devices from other National product lines — such as the Bipolar Memory and Octal Logic devices found in this book — and certain proprietary functions, such as the 29903  $16 \times 4$  Edge-Triggered Register File.

Even more significantly, National will begin to develop new bit-slices and microsequencers that are architecturally different from other products on the market.

These products, plus other products currently in development, make use of the SCL design philosophy. By using SCL, National has not only set a standard of performance for the 2900 Family that other manufacturers are attempting to duplicate, but also is providing you—the design engineer—with components that allow you to build the highest performance systems possible using bipolar LSI technology.

SCL is a design technique that combines the performance advantages of ECL with Low Power Schottky input and output compatibility. For a more detailed description, see the Applications section.



## 2900 Family/ Bipolar Microprocessor

## IDM2901A, IDM2901A-1/IDM2901A-2 4-Bit Bipolar Microprocessor

#### **General Description**

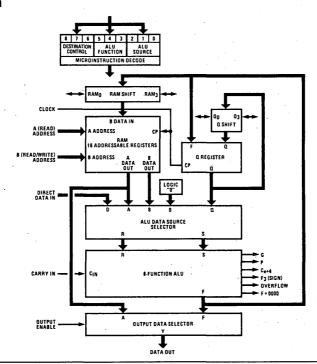
The IDM2901 4-bit bipolar microprocessor slice is a cascadable device designed for use in Central Processing Units, programmable microprocessors, peripheral controllers, and other "high-speed" applications where economy, hardware/software flexibility, and easy expansion are system prerequisities. The building-block architecture and microinstruction format of the IDM2901 permit efficient emulation of most digital-based systems.

As shown in the simplified block diagram, the IDM2901 device consists of a 16-word by 4-bit 2-port RAM, a high-speed ALU, and the required shifting, decoding, and multiplexing circuits. The 9-bit microinstruction word is organized into three groups of three bits each the first group (bits 0 - 2) selects ALU source operands, the second group (bits 3 - 5) selects the ALU function, and the last group (bits 6 - 8) selects the destination register within the ALÚ. The slice microprocessor is cascadable with full look-ahead or ripple carry; all outputs are TRI-STATE® and four status-flag outputs are available. To minimize power consumption and to maximize speed and reliability, the 40-pin LSI chip is fabricated using a National state-of-the-art Low-Power Schottky technology called "SCL".

#### Features and Benefits

- Multiple-address architecture improves system speed by providing simultaneous yet independent access to two working registers.
- Multifunction ALU performs addition, two subtraction operations, and five logic functions on two source operands.
- Flexible data-source selection for every ALU function, data is selected from five source ports for a total of 203 source operand pairs.
- Left/right shift independent of ALU an arithmetic operation and a left or right shift can be obtained on the same machine cycle.
- Four status flags carry, overflow, zero, and functional sign are available as outputs.
- Expandable Connect any number of IDM2901s together for longer word lengths.
- Microprogrammable three groups of 3 bits each for source operand, ALU function, and destination control.

#### **Block Diagram**



### **Absolute Maximum Ratings**

Storage Temperature Temperature (Ambient) Under Bias Supply Voltage to Ground Potential

DC Voltage Applied to Outputs for High Output State

DC Input Voltage
DC Output Current, into Outputs
DC Input Current

-65°C to +150°C -55°C to +125°C

-0.5 V to +6.3 V

-0.5 V to +V<sub>CC</sub> max -0.5 V to +5.5 V 30 mA -30 mA to +5.0 mA

#### **Operating Range**

IDM2901 JC, NC IDM2901 JM, JM/883 IDM2901A-1 JC, NC

P/N

 $T_A = 0^{\circ} C \text{ to } +70^{\circ} C$   $T_C = -55^{\circ} C \text{ to } +125^{\circ} C$   $T_A = 0^{\circ} C \text{ to } +70^{\circ} C$ 

Temperature

4.75V to 5.25V 4.50V to 5.50V 4.75V to 5.25V

Vcc

#### Standard Screening (Conforms to MIL-STD-883 for Class C parts)

	MIL-STD-883		Le	evel
Step	Method Conditions		JC, NC	JM
Pre-Seal Visual Inspection	2010	В	100%	100%
Stabilization Bake	1008	C: 24-hour 150°C	100%	100%
Temperature Cycle	1010	C: -65°C to +150°C 10 cycles	100%	100%
Centrifuge	2001	B: 10,000 G	100%*	100%
Fine Leak	1014	A: 5 x 10 <sup>-8</sup> atm-cc/cm <sup>3</sup>	100%*	100%
Gross Leak	1014	C2: Fluorocarbon	100%*	100%
Electrical Test Subgroups 1 and 7 and 9	5004	See below for definitions of subgroups	100%	100%
Insert Additional Screening h	ere for Class B Part	s		
Group A Sample Tests				
Subgroup 1			LTPD = 5	· LTPD = 5
Subgroup 2			LTPD = 7	LTPD = 7
Subgroup 3	FOOE	See below for	LTPD = 7	LTPD = 7
Subgroup 7	5005	definitions of subgroups	LTPD = 7	LTPD = 5
Subgroup 8		.	LTPD = 7	LTPD = 7
Subgroup 9		·	LTPD = 7	LTPD = 5

<sup>\*</sup>Not applicable to IDM2901ANC.

### Additional Screening for Class B Parts

	MIL-STD-883		Level	
Step	Method	Conditions	JM/883	
Burn-In	1015	D: 125°C, 160 hours min	100%	
Electrical Test	5004			
Subgroup 1		i l	100%	
Subgroup 2			100%	
Subgroup 3	 	1	100%	
Subgroup 7		1	100%	
Subgroup 9		1	100%	

### **Group A Subgroups**

(as defined in MIL-STD-883, method 5005)

Subgroup	Parameter	Temperature
1	DC	25°C
2	DC	Maximum rated temperature
3	DC	Minimum rated temperature
7	Function	25°C
8	Function	Maximum and minimum rated temperature
9	Switching	25°C
10	Switching	Maximum rated temperature
11	Switching	Minimum rated temperature

### Electrical Characteristics Over Operating Range IDM2901A/IDM2901A-1

Symbol	Description	Test Cond	Test Conditions (Note 1)			Max	Units
			I <sub>OH</sub> = -1.6 mA; Y <sub>0</sub> /Y <sub>1</sub> /Y <sub>2</sub> /Y <sub>3</sub>	2.4			
			IOH = -1.0 mA; Cn+4	2.4			
Voн	Output High Voltage	VCC = min	IOH = -800 μA; OVR/P	2.4			] v
٧ОН	Output riight voltage	VIN = VIH or VIL	IOH = -600 μA; F3	2.4			] ' '
			$I_{OH} = -600 \mu\text{A};$ RAM <sub>0,3</sub> /Q <sub>0,3</sub>	2.4			
			IOH = -1.6 mA; G	2.4			7

### Electrical Characteristics (cont'd.)

Symbol		Те	st Con	ditions (N	lote 1)	Min	Typ (Note 2)	Max	Units				
ICEX	Output Leakage Current for F = 0 Output	VCC = min;	V <sub>OH</sub> ≃	5.5 V, V	IN = VIH or VIL			250	μΑ				
				Y0/Y1/				0.5					
				IOL = 1 Y0/Y1/	6 mA (Mil); Y2/Y3			0.5					
VOL	Output Low Voltage	VCC = min;			$6 \text{ mA}$ ; $\overline{G}/F = 0$			0.5	] v				
, VOL	VOL Sutput Low Voltage	$\Lambda IM = \Lambda IH c$	r VIL		0 mA; C <sub>n+4</sub>			0.5					
				I <sub>OL</sub> = 1 OVR/P	0 mA;			0.5					
·				IOL = 8	mA; M <sub>0,3</sub> /Q <sub>0,3</sub>		·	0.5	·				
VIH	Input High Level	Guaranteed inputs	nput lo	ogical high	voltage for all	2.0			V				
VIL	Input Low Level	inputs			voltage for all			0.8	V				
VI	Input Clamp Voltage	VCC = min;	IN = -					-1.5	V				
				Clock/C				-0.36	1				
				A <sub>0</sub> /A <sub>1</sub> /				-0.36	1				
			B <sub>0</sub> /B <sub>1</sub> /I				-0.36						
†iL	Input Low Current	V <sub>CC</sub> = max; V <sub>IN</sub> = 0.5 V		5 V I <sub>0</sub> /I <sub>1</sub> /I <sub>2</sub> /I <sub>6</sub>			-0.36	mA .					
								-0.36	1				
				13/14/15 17/18				-0.36					
,								-0.36	1				
	<u> </u>				3/Q <sub>0,3</sub> (Note 4)			-0.36					
				Clock/C				20	1				
	* *	V <sub>CC</sub> = max; V <sub>IN</sub> = 2.7 V		A <sub>0</sub> /A <sub>1</sub> /A <sub>2</sub> /A <sub>3</sub>				20					
								B <sub>0</sub> /B <sub>1</sub> /I				20	
Iн	Input High Current							D <sub>0</sub> /D <sub>1</sub> /				.20	μΑ
. ""						10/11/12				20			
						13/14/15				20			
	1 .			RAM <sub>0,3</sub> /Q <sub>0,3</sub> (Note 4)				100					
·				Cn				20					
<u> </u>	Input High Current	VCC = max;						1.0	mA				
			Y <sub>0</sub> /Y	1/Y2/Y3	$V_0 = 2.4 \text{ V}$ $V_0 = 0.5 \text{ V}$			50	4				
los:	Off Cases / Wink American				V <sub>O</sub> = 0.5 V			-50					
	Off State (High Impedance) Output Current	VCC = max	RAM	<sub>0,3</sub> /Q <sub>0,3</sub>	V <sub>O</sub> = 2.4 V (Note 4)			100	μΑ				
			·		V <sub>O</sub> = 0.5 V (Note 4)			-360					
					Y2/Y3/G	-30		-85	1				
	Output Short Circuit Current	V <sub>CC</sub> = 5.75	v <u> </u>	Cn+4		-30		-85	1				
Ios	(Note 3)	V <sub>O</sub> = 0.5 V	·	OVR/P		-30		-85	mA .				
		-		F <sub>3</sub>		-30		-85					
					3/Q <sub>0,3</sub>	-30		-85					
			L	TA = 25			160	245	mA				
			JC		C to +70°C		160	260					
ICC	Power Supply Current (Note 6)	ACC = wax	-	T <sub>A</sub> = +7		<u> </u>	160	220	mA mA				
			JM	-	5°C to +125°C	1	160	275					
			1 -	T <sub>C</sub> = +1	25°C	1	160	185	1				

Note 1: For conditions shown as min or max, use the appropriate value specified under Electrical Characteristics for the applicable device type.

Note 2: Typical limits are at  $V_{CC} = 5.0 \text{ V}$ ,  $25^{\circ}\text{C}$  ambient, and maximum loading.

Note 3: Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.

Note 4: These are TRI-STATE outputs internally connected to PNP inputs. Input characteristics are measured with I<sub>6,7,8</sub> in a state such that the TRI-STATE output is off (high-impedance).

Note 5: "Mil" = IDM2901 JM, JM/883; "Com'l" = IDM2901 JC, NC.

Note 6: Worst case ICC is at minimum temperature.

#### **Absolute Maximum Ratings**

Storage Temperature
Temperature (Ambient) Under Bias
Supply Voltage to Ground Potential
DC Voltage Applied to Outputs for

High Output State
DC Input Voltage
DC Output Current, into Outputs

DC Input Current

-0.5 V to +6.3 V -0.5 V to +V<sub>CC</sub> max -0.5 V to +5.5 V

-30 mA to +5.0 mA

-65°C to +150°C

-55°C to +125°C

30 mA

Operating Range

P/N IDM2901A-2 JC, NC IDM2901A-2 JM IDM2901A-2 JM/883 Temperature  $T_A = 0^{\circ}C \text{ to } +70^{\circ}C$   $T_C = -55^{\circ}C \text{ to } +125^{\circ}C$   $T_C = -55^{\circ}C \text{ to } +125^{\circ}C$ 

VCC 4.75V to 5.25V 4.50V to 5.50V 4.50V to 5.50V

Standard Screening (Conforms to MIL-STD-883 for Class C parts)

	MIL-STD-883		L	evel	
Step	Method	Conditions	JC, NC	JM	
Pre-Seal Visual Inspection	2010	В	100%	100%	
Stabilization Bake	1008	C: 24-hour 150°C	100%	100%	
Temperature Cycle	1010	C: -65°C to +150°C 10 cycles	100%	100%	
Centrifuge	2001	B: 10,000 G	100%*	100%	
Fine Leak	1014	A: 5 x 10 <sup>-8</sup> atm-cc/cm <sup>3</sup>	100%*	100%	
Gross Leak	1014	C2: Fluorocarbon	100%*	100%	
Electrical Test Subgroups 1 and 7 and 9	5004	See below for definitions of subgroups	100%	100%	
nsert Additional Screening h	ere for Class B Part	s		<del>1</del>	
Group A Sample Tests Subgroup 1 Subgroup 2 Subgroup 3 Subgroup 7 Subgroup 8 Subgroup 9	5005	See below for definitions of subgroups	LTPD = 5 LTPD = 7 LTPD = 7 LTPD = 7 LTPD = 7 LTPD = 7	LTPD = 5 LTPD = 7 LTPD = 7 LTPD = 5 LTPD = 7 LTPD = 5	

<sup>\*</sup>Not applicable to IDM2901A-2 NC

### Additional Screening for Class B Parts

Step	MIL-STD-883 Method		
Burn-In	1015	D: 125°C, 160 hours min	100%
Electrical Test	5004		
Subgroup 1		İ	100%
Subgroup 2			100%
Subgroup 3	İ		100%
Subgroup 7		1	100%
Subgroup 9		į	100%

### Group A Subgroups

(as defined in MIL-STD-883, method 5005)

Subgroup	Parameter	Temperature
1	DC	25°C
2	DC	Maximum rated temperature
3	DC	Minimum rated temperature
7	Function	25°C
8	Function	Maximum and minimum rated temperature
9	Switching	25°C
10	Switching	Maximum rated temperature
11	Switching	Minimum rated temperature

### Electrical Characteristics Over Operating Range IDM2901A-2

Symbol	Description	tion Test Conditions (Note 1)			Typ (Note 2)	Max	Units
			$I_{OH} = -1.6 \text{ mA};$ $Y_0/Y_1/Y_2/Y_3$	2.4		,	
			IOH = -1.0 mA; Cn+4	2.4			
VOH	Output High Voltage	VCC = min	IOH = -800 μA; OVR/P	2.4			] ,
VOH	Output riigh Voltage	VIN = VIH or VIL	IOH = -600 μA; F3	2.4			] *
			$I_{OH} = -600 \mu\text{A};$ RAM <sub>0,3</sub> /Q <sub>0,3</sub>	2.4			
			IOH = -1.6 mA; G	2.4			1

#### Electrical Characteristics (continued)

Symbol	Description	Test Conditions (Note 1)			Min	Typ (Note 2)	Max	Units			
ICEX	Output Leakage Current for F = 0 Output	VCC = min;	V <sub>OH</sub> = 5	.5 V, V	IN = VIH or VIL			250	μΑ		
•			I <sub>OL</sub> = 20 mA (Com'l) Y <sub>0</sub> /Y <sub>1</sub> /Y <sub>2</sub> /Y <sub>3</sub>		Y2/Y3			0.5			
					6mA (Mil); 'Y2/Y3			0.5			
Va	VOL Output Low Voltage	VCC = min;	[7	OL = 1	6 mA; G/F = 0			0.5	] v		
VOL	Output Low Voltage	VIN = VIH o	or VIL [	OL = 1	0 mA; C <sub>n+4</sub>			0.5	] *		
				OVR/P	0 mA;			0.5			
,				OL = 8	3 mA; M0,3/Q0,3			0.5			
Vін	Input High Level	Guaranteed i inputs	nput log	ical hig	h voltage for all	2.0			V		
· <del>-</del>	Input Low Level	Guaranteed i inputs	nput log	ical low	voltage for all			0.8	V		
v <sub>1</sub>	Input Clamp Voltage	VCC = min; I						-1.5	V		
			-	Clock/C				-0.36			
		V <sub>CC</sub> = max; V <sub>IN</sub> = 0.5 V		A <sub>0</sub> /A <sub>1</sub> /A <sub>2</sub> /A <sub>3</sub> B <sub>0</sub> /B <sub>1</sub> /B <sub>2</sub> /B <sub>3</sub>				-0.36			
								-0.36	1		
IIL	Input Low Current			D <sub>0</sub> /D <sub>1</sub> /D <sub>2</sub> /D <sub>3</sub>				-0.36	mA		
	Wilder Zow Garrent			10/11/12/16				-0.36			
			h	13/14/15				-0.36			
				17/18				-0.36	1		
					3/Q <sub>0,3</sub> (Note 4)			-0.36			
		Clock/OE A <sub>0</sub> /A <sub>1</sub> /A <sub>2</sub> /A <sub>3</sub>				20					
								20	4		
			- r	B <sub>0</sub> /B <sub>1</sub> /				20	1		
чн	Input High Current	VCC = max;	-		D <sub>2</sub> /D <sub>3</sub>			20	μА		
		VIN = 2.7 V		VIN = 2.7 V		10/11/1:				20	1
			<u> </u>	13/14/15				20			
					3/Q <sub>0,3</sub> (Note 4)			100	1		
···		<del></del>	Cn					20			
	Input High Current	VCC = max;	VIN = 5.	.5 V	11/2 - 0.414			1.0	mA		
			Y <sub>0</sub> /Y <sub>1</sub> /	Y2/Y3	Vo = 2.4 V			50	-		
lozu	Off State (High Impedance)		~		VO - 0.5 V			-50	1		
	Output Current	ACC = wax	RAM <sub>0,3</sub>	3/Q <sub>0.3</sub>	V <sub>O</sub> = 2.4 V (Note 4)			100	μΑ		
<del></del>			<b></b>		V <sub>O</sub> = 0.5 V (Note 4)			-360			
					Y2/Y3/G '	-30		-85	1		
	Output Short Circuit Current	V <sub>CC</sub> = 5.75 \	//	Cn+4		-30		-85	<b>.</b>		
IOS	(Note 3)	V <sub>O</sub> ≈ 0.5 V	<u> </u>	OVR/P		-30		-85	mA <sup>°</sup>		
			L	F <sub>3</sub>		-30		-85	1		
				RAM <sub>0,3</sub> /Q <sub>0,3</sub>		-30		-85	<b>_</b>		
				TA = 2			160	250	<del> </del>		
1cc	Power Supply Current (Note 6)	Vcc = max	-		°C to +70°C	ļ	160	265	1		
			I IMI	T <sub>C</sub> = -55°C to +125°C		ľ	160	280	mA		
	'		1	T <sub>C</sub> = +125°C		,	160	190	1		

Note 1: For conditions shown as min or max, use the appropriate value specified under Electrical Characteristics for the applicable device type.

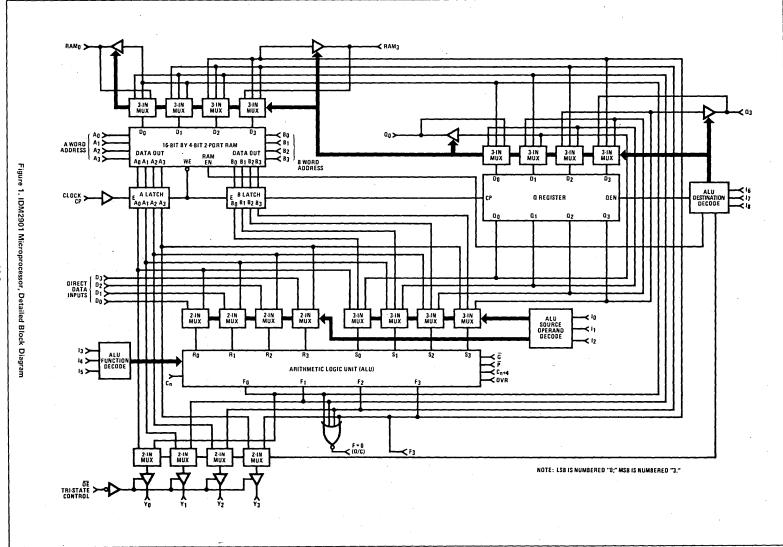
Note 2: Typical limits are at  $V_{CC} = 5.0 \, V$ ,  $25^{\circ} \, C$  ambient, and maximum loading.

Note 3: Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.

Note 4: These are TRI-STATE outputs internally connected to PNP inputs. Input characteristics are measured with 16,7,8 in a state such that the TRI-STATE output is off (high-impedance).

Note 5: "Mil" = IDM2901A-2 JM, JM/883; "Com'l" = IDM2901A-2 JC, NC.

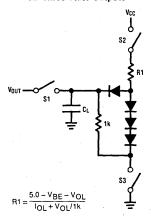
Note 6: Worst case I<sub>CC</sub> is at minimum temperature.



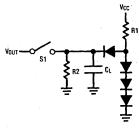
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#### Test Output Load Configurations for IDM2901A, A-1, A-2

#### A. Three-State Outputs



#### **B. Normal Outputs**



$$R2 = \frac{2.4V}{10.11}$$

$$R1 = \frac{5.0 - V_{BE} - V_{OL}}{1_{OL} + V_{OL}/R2}$$

C. Open-Collector Outputs



$$R1 = \frac{5.0 - V_{OI}}{I_{OL}}$$

Note 1: C<sub>1</sub> = 50 pF includes scope probe, wiring and stray capacitances without device in test fixture.

Note 2: S1, S2, S3 are closed during function tests and all AC tests except output enable tests.

Note 3: S1 and S3 are closed while S2 is open for tpzH test.

S1 and S2 are closed while S3 is open for  $tp_{ZL}$  test. Note 4:  $C_L = 5.0$  pF for output disable tests.

#### **TESTING CONSIDERATIONS**

Incoming test procedures on this device should be carefully planned, taking into account the high complexity and power levels of the part. The following notes may be

- Insure the part is adequately decoupled at the test head. Large changes in V<sub>CC</sub> current as the device switches may cause erroneous function failures due to V<sub>CC</sub> changes.
- Do not leave inputs floating during any tests, as they may start to oscillate at high frequency.
- 3. Do not attempt to perform threshold tests at high speed. Following an input transition, ground current may change by as much as 400 mA in 5 ns-8 ns. Inductance in the ground cable may allow the ground pin at the device to rise by 100s of millivolts momentarily.
- 4. Use extreme care in defining input levels for AC tests. Many inputs may be changed at once, so there will be significant noise at the device pins and they may not actually reach V<sub>IL</sub> or V<sub>IH</sub> until the noise has settled. National recommends using V<sub>IL</sub> ≤ 0.4V and V<sub>IH</sub> ≥ 2.4V for AC tests.
- To simplify failure analysis, programs should be designed to perform DC, Function, and AC tests as three distinct groups of tests.

### Test Output Loads for IDM2901A, A-1, A-2

Pin #	Pin Label	Test Circuit	R1	R2
3	RAM <sub>3</sub>	Α	560	1k
5	RAM <sub>0</sub>	Α	560	1k
7	F = 0	С	270	_
13	$Q_3$	Q <sub>3</sub> A		1k
18	$Q_0$	Α	560	1k
28	F <sub>3</sub>	В	-620	3.9k
29	G	В	220	1.5k
30	C <sub>n+4</sub>	В	360	2.4k
31	OVR	В	470	3k
32	Р	В	470	3k
33-36	Y <sub>0-3</sub>	Α	220	1k

#### **Architecture**

Figure 1 shows a detailed block diagram of the IDM2901. Observe that all data paths are 4 bits wide; however, the 4-bit slice can be cascaded to the number of bits required for a particular application. Although all parts of the bipolar device are important, the two key elements are the 16-word by 4-bit 2-port RAM and the high-speed ALU.

Any one of the 16 words in RAM can be read from the A-port (A<sub>3</sub>-A<sub>0</sub>) or the B-port (B<sub>3</sub>-B<sub>0</sub>); the selected word for the A-port is determined by the 4-bit A-address field, whereas the B-address field controls the output of the B-port. If the two address codes are identical, the same file data appears simultaneously at both output ports (A and B).

When enabled by RAM EN, new data is written into the file "word" defined by the B-address field; the write function is implemented when the clock input is low.

Each bit of data to be written is input via a 3-input multiplexer; this scheme permits shifting up one bit position (from LSB towards MSB), shifting down one bit position (from MSB towards LSB), or not shifting at all. A similar scheme is used when data is written into the "Q" register.

Each of the A and B data ports drives an associated 4-bit latch. These latches hold the RAM data while the clock input is low; consequently, any possibility of race conditions when writing new data is eliminated.

The high-speed ALU can perform three binary arithmetic and five logic operations on the two 4-bit input words (R<sub>3</sub> - R<sub>0</sub> and S<sub>3</sub> - S<sub>0</sub>). The R-input field is driven from a 2-input multiplexer, whereas the S-input field is driven by a 3-input multiplexer. Both the R- and S-multiplexers

have an inhibit capability, where no data is passed — this is equivalent to a "zero" source operand. Referring to figure 1, observe that the A-port output of the RAM and the 4-bit direct-data inputs (D3 - D0) are connected to the R-input multiplexers; the S-input multiplexer has three inputs — one from the A-port of RAM, one from the B-port of RAM, and one from the O-register.

With the foregoing input-multiplexer scheme, the inputs (A, B, D, Q, and "Zero"), when taken in pairs, provide any one of ten source operands for the ALU - AB, AD, AQ, AO, BD, BQ, BO, DQ, DO, and QO. When the A and B address fields for RAM are identical, it is clear that certain combinations (AD/BD, AQ/BQ, and A0/B0) are redundant; that is, the identical function is implemented for either operand. Only seven of the combinations are completely nonredundant. Eight of the ten combinations (source operands) are implemented by the IDM2901A microprocessor. The ALU source operands are selected by three microinstruction inputs - In, I1, and 12. These inputs are defined in figure 2. Each of the preceding D and Q operands provides an essential function. The D input (direct-data) is used to load the working registers inside the 2901 device; also, this input source can be used to modify data files within the ALU. The Q-register is an internal 4-bit data source that is well suited for a multiply/divide operation; however, for some applications, it can be used as a data-holding register or as an accumulator.

The ALU is a high-speed arithmetic/logic operator that is capable of performing three binary arithmetic functions and five logic functions. Three microinstruction inputs (13, 14, and 15) are used to select one of the eight functions; these inputs, along with their octal codes, are defined in figure 3.

	Micro	ALU Source Operands			
l <sub>2</sub>	l <sub>1</sub>	I <sub>0</sub>	Octal Code	R	S
L	L	L	0	Α	Q
L	L	н	· 1	Α	В
L	н	L	2	0	Q
L	н	Н	3	0	В
Н	L	L	4	0	Α
Н	L	н	5	D .	Α
н	Н	L	6	D	Q
Н	н	н	7	D	0

Figure 2. ALU Source Operand Control

	Mici	ro Code	<b>:</b>	ALU	Symbol		
15	14	13	Octal Code	Function	Symbol		
L	L	L	0	R Plus S	R + S		
L	L	Н	1	S Minus R	S – R		
L	н	L	2	R Minus S	R – S		
L.	н	н	3	RORS	RVS		
Н	L	L	4	RANDS	RΛS		
Н	L	Н	5	RANDS	RΛS		
Н	н	L	6	R EX-OR S	R₩S		
Н	Н	Н	7	R EX-NOR S	R₩S		

Figure 3. ALU Function Control

Normally, the look-ahead carry mode is used when cascading the ALUs of several microprocessor devices. The carry generate  $(\overline{G})$  and carry propagate  $(\overline{P})$  outputs are suitable for use in a carry-look-ahead generator. A carry-out (Cn+4) is also generated and is available for use as the carry flag in a status register or as a ripplecarry output. Both carry-in (Cn) and carry-out (Cn+4) are active-high signals. Three other status-oriented outputs are available from the ALU; these are F3, F = 0, and overflow (OVR). The F3 output is the most significant (sign) bit of the ALU, and, without enabling the TRI-STATE outputs, it can be used to determine positive or negative results. When enabled, the logic level of F3 is identical to that of sign bit Y3. The F = 0 output is used for zero detect; F = 0 is high when all F outputs are low. The F = 0 output is of the open-collector type and can be wire ORed between microprocessor slices. The overflow (OVR) output is used to flag arithmetic operations that exceed the available twos-complement number range. When an overflow exists (Cn+3 and Cn+4 are of opposite polarity), the OVR output is high.

Outputs from the ALU can be stored in the register file or the O register, or can be transmitted to the outside world. Eight possible destination codes are defined by microinstruction inputs  $1_6$ ,  $1_7$ , and  $1_8$ ; the various destination control codes are shown in figure 4. The 4-bit data field (Y3 - Y0) is a TRI-STATE output that can be directly bus organized. The Y outputs are enabled by  $\overline{\text{OE}}$ ; when this control signal is high, the Y-outputs are TRI-STATEd. A 2-input multiplexer is also used at the Y-output port to select either the A port of RAM or the F output of the ALU; this selection is controlled by the previously described microinstruction inputs ( $1_6$ ,  $1_7$ , and  $1_8$ ).

As previously described, the RAM inputs (register file) are driven by a 3-input multiplexer. Thus, outputs from the ALU can be entered nonshifted, shifted up (towards MSB) one position (x 2), or shifted down (towards LSB) one position (÷2). The shifter is equipped with two ports — RAM0 and RAM3; both ports consist of a TRI-STATE buffer-driver, each of which supplies one input to the foregoing multiplexer. In the shift-up (x 2) mode, the RAM0 output driver and the RAM0 multiplexer input are enabled, whereas in the shift-down (÷2) mode, the RAM0 output driver and RAM3 multiplexer

input are enabled; in the no-shift mode, both drivers are TRI-STATE and neither multiplexer input is enabled. The shifter is controlled by the I<sub>6</sub>, I<sub>7</sub>, and I<sub>8</sub> microinstruction inputs.

The Q register likewise is driven from a 3-input multiplexer and the Q shifter is equipped with two input/output ports — QQ and Q3. Operation of these two ports is similar to that of the RAM shifter, and the ports are controlled by I6, I7, and I8. In the shift-up or shift-down modes, the Q register is shifted in a specified direction with the input/output terminals of the register being an input (for a shift-up) or an output (for a shift-down). In the no-shift mode, the multiplexer may enter the ALU data into the Q register; in this case, input/output lines of the register are TRI-STATE.

The clock input shown in figure 1 controls the RAM, the A and B latches, and the Q register. When the clock input is high, the A and B latches are open and data from the RAM outputs is allowed to pass through to the ALU or "Y" outputs. When the clock input is low, both latches are closed and the last data entered is retained. When the clock input is low and if the input control code (I6, I7, and I8) has enabled a file-write operation, new data, as defined by the 4-bit B-address field, is written into the RAM file. When enabled, data is clocked into the Q register on the low-to-high transition of the clock pulse.

#### Source Operands and ALU Functions

Any one of eight source operand pairs can be selected by instruction inputs  $I_0$ ,  $I_1$ , and  $I_2$  for use by the ALU; instruction inputs  $I_3$ ,  $I_4$ , and  $I_5$  then control function selection for the ALU – five logic and three arithmetic functions. In the arithmetic mode, the carry input  $(C_n)$  also affects the ALU functions; the carry input has no effect on the "F" result in the logic mode. These control parameters  $(I_6-I_0$  and  $C_n)$  are summarized in figure 5 to completely define the ALU/source operand functions.

The ALU functions can also be examined on a task basis: that is, add, subtract, AND, OR, and so on. Again, in the arithmetic mode, the carry input will affect the result, whereas in the logic mode it will not. Figures 6 and 7, respectively, define the various logic and arithmetic functions of the ALU; both carry states ( $C_n = 0/C_n = 1$ ) are defined in the function matrices.

	Mic	cro Co	de	RAM	Function	Q-Reg	. Function	V	RAM	Shifter	Q Shifter	
Ιg	17	16	Octal Code	Shift	Load	Shift	Load	Output	RAM <sub>0</sub>	RAM3	α <sub>0</sub>	Ω3
L	L	L	0	X	None	None	F → Q	F	×	×	×	×
L	L	Н	1	X	None	×	None	F	Х	×	×	·×
L	Н	L	2	None	F→B	×	None	Α	Х	×	×	×
L	Н	. н	3	None	F→B	X	None	F	X	X	×	Х
Н	L	L	4	Down	F/2 → B	Down	Q/2 → Q	F	F <sub>0</sub>	IN <sub>3</sub>	Q <sub>0</sub>	IN3
Н	L	Н	5	Down	F/2.→ B	×	None	F	F <sub>0</sub>	IN <sub>3</sub>	$Q_0$	X
Н	Н	L	6	Up	2F → B	Up	2Q → Q	F	IN <sub>0</sub>	F3	INO	Ω3
Н	Н	Н	7	Up	2F → B	Х	None	F	INo	F <sub>3</sub>	X	Q3 .

Figure 4. ALU Destination Control

X = Don't care. Electrically, the shift pin is a TTL input internally connected to a TRI-STATE output which is in the high-impedance state.

B = Register Addressed by B inputs.

Up is toward MSB, Down is toward LSB.

			Figure 5. So	urce Operand	and ALU Fun	ction Matrix			
	12,1,0 Octal	0	1	2	3	4	5	6	7
Octal 15,4,3	ALU Source ALU Function	Α, Q	А, В	ο, α	О, В	O, A	D, A	D, Q	D, O
0	C <sub>n</sub> = L	A + Q	A + B	Q	В	А	D+A	D + Q	D
U	R Plus S C <sub>n</sub> = H	A+Q+1	A + B + 1	Q + 1	B + 1	A + 1	D+A+1	D+Q+1	D + 1
1	C <sub>n</sub> = L S Minus R	Q - A - 1	B - A - 1	Q - 1	B - 1	A - 1	A - D - 1	Q - D - 1	- D - 1
ı	C <sub>n</sub> = H	Q – A	B - A	Q	В	Α -	A – D	Q - D	- D
2	C <sub>n</sub> = L R Minus S	A - Q - 1	A - B - 1	- Q - 1	– B – 1	- A - 1	D - A - 1	D - Q - 1	D - 1
2	C <sub>n</sub> = H	A - Q	A - B	- a	– B	- A	D - A	D - Q	-D
3	R OR S	DVA	AVB	Q	. В	А	DVA	DVQ	D
4	R AND S	ΑΛΩ	ΑΛВ	0	0	0	DAA	DVO	. 0
5	RANDS	ĀΛQ	ĀΛB	Q	В	А	DΛΑ	DΛQ	0
6	R EX-OR \$	-A ₩ Q	А₩В	Q	В	А	D₩A	D₩Q	D
7	R EX-NOR S	Ā₩Q	Ā₩B	ā	B	Ā	D∀A	D₩Q	Ď

<sup>+ =</sup> Plus; - = Minus; V = OR,  $\Lambda = AND$ ;  $\forall = EX-OR$ .

Figure 6. ALU Logic Mode Functions (Cn Irrelevant)

Octal  5,4,3/ 2,1,0	Group	Function
40 41 45 46	AND	A A Q A A B D A A D A Q
30 31 35 36	OR	A V Q A V B D V A D V Q
60 61 65 66	EX-OR	A ¥ Q A ¥ B D ¥ A D ¥ Q
70 71 75 76	EX-NOR	A ¥ Q A ¥ B D ¥ A D ¥ Q
72 73 74 77	INVERT	<u>G</u> 8 A D
62 63 64 67	PASS	Q B A D
32 33 34 37	PASS	Q B A D
42 43 44 47	"ZERO"	0 0 0
50 51 55 56	MASK	Ā ^ Q Ā ^ B D ^ A D ^ Q

Figure 7. ALU Arithmetic Mode Functions

Octal	C <sub>n</sub> = 0	(Low)	C <sub>n</sub> = 1 (High)		
<sup>l</sup> 5,4,3/ <sup>l</sup> 2,1,0	Group	Function	Group	Function	
00 01 05 06	ADD	A + Q A + B D + A D + Q	ADD plus one	A + Q + 1 A + B + 1 D + A + 1 D + Q + 1	
02 03 04 07	PASS	Q B A D	Increment	Q+1 B+1 A+1 D+1	
12 13 14 27	Decrement	Q - 1 B - 1 A - 1 D - 1	PASS	Q B A D	
22 23 24 17	1s Comp	- Q - 1 - B - 1 - A - 1 - D - 1	2s Comp (Negate)	- Q - B - A - D	
10 11 15 16 20 21 25 26	Subtract (1s Comp)	Q - A - 1 B - A - 1 A - D - 1 Q - D - 1 A - Q - 1 A - B - 1 D - A - 1 D - Q - 1	Subtract (2s Comp)	Q - A B - D Q - D A - B D - A D - Q	

#### **Pinout Descriptions of IDM2901**

Pin functions for the IDM2901 4-bit slice microprocessor are as follows:

- A3-A0

  4-bit address field used to select one of the file registers whose contents are displayed through the A port of RAM.
- B3-B0

  4-bit address field used to select one of the file registers whose contents are displayed through the B port of RAM. When the clock is low, new data can be written into the selected B-port register.
- Ig-I0 Nine instruction-control lines I<sub>0</sub>/I<sub>1</sub>/I<sub>2</sub> determine data sources of ALU, I<sub>3</sub>/I<sub>4</sub>/I<sub>5</sub> select ALU function, and I<sub>6</sub>/I<sub>7</sub>/I<sub>8</sub> select data inputs for the Q register or the register
- Q3/RAM3 Serves as shift data input/output lines for the most significant bit (MSB) of Q register (Q3) and the register stack (RAM3). These lines are TRI-STATE outputs that connect to TTL inputs within the IDM2901 device. When the destination code, as defined by 16/17/18, indicates an up-shift (octal 6 or 7), the TRI-STATE outputs are enabled; accordingly, the MSB of the Q register is available on the Q3 pin and the MSB of the ALU output is available on the RAM3 pin. Otherwise, these output lines are TRI-STATE or serve as LS-TTL inputs. When a down-shift is indicated by the destination code, the Q3 and RAM3 pins are used as data inputs to the MSB of the Q register or RAM.
- Q<sub>0</sub>/RAM<sub>0</sub> These shift lines are similar to Q<sub>3</sub> and RAM<sub>3</sub>, except they operate on the least significant bit (LSB) of the Q register and RAM. To transfer data for up- and down-shifts of the Q register and the ALU, the Q<sub>0</sub> and RAM<sub>0</sub> pins are connected, respectively, to the next less-significant device (Q<sub>n</sub> and RAM<sub>n</sub>) in the cascaded chain.
- D3-D0 A 4-bit data field that can be selected as a source of external data for ALU D0 is the least significant bit.
- Y3-Y0

  4-bit output data of IDM2901. These lines are TRI-STATE; when enabled, they provide either the ALU output or data from the A port of the register file the selected source is determined by the destination code, as defined by I<sub>6</sub>, I<sub>7</sub>, and I<sub>8</sub>.

- When the Output Enable (OE) signal is high, the Y outputs are inactive; when the signal is active-low, the active high or low outputs are enabled.
- P/G Carry generate and propagate outputs see figure 8 for logic equations.
- OVR The overflow flag corresponds to the exclusive-OR of the carry-in and carry-out of the MSB of the ALU. When set high, it indicates that the result of an arithmetic twos-complement operation has overflowed into the sign bit see figure 8 for the logic equation.
- F=0 An open-collector output that goes high if all data lines (F3-F0) are low, that is, the result of an ALU operation is zero.
- C<sub>n</sub> Carry-in to ALU.
- C<sub>n+4</sub> Carry-out of ALU see figure 8 for logic equations.
- CP Clock input. Outputs of Q register and file are clocked on low-to-high transition; the low interval of the clock input corresponds to the "write enable" period of the 16-by-4 RAM, that is, the "master" latches of the register file. When the clock is low, the output latches store the data previously held at the RAM outputs; thus, synchronous master-slave operation of the register file is permitted.
- F3 Most significant (sign) bit output of the

# Logic Functions for G, P, Cn+4, and OVR

When the IDM2901 is in the add or the subtract mode, four signals (G, P,  $C_{n+4}$ , and OVR) are available to indicate carry and overflow conditions. Based on the eight ALU functions, logic equations for these signal are shown in figure 8. (Note: The "R" and "S" inputs are selected according to figure 2.)

Definitions (+ = OR):

 $P_0 = R_0 + S_0$   $G_0 = R_0 S_0$  $P_1 = R_1 + S_1$   $G_1 = R_1 S_1$ 

P<sub>2</sub> = R<sub>2</sub> + S<sub>2</sub> G<sub>2</sub> = R<sub>2</sub>S<sub>2</sub> P<sub>3</sub> = R<sub>3</sub> + S<sub>3</sub> G<sub>3</sub> = R<sub>3</sub>S<sub>3</sub>

 $\begin{aligned} &C_4 = G_3 + P_3G_2 + P_3P_2G_1 + P_3P_2P_1G_0 + P_3P_2P_1P_0C_n \\ &C_3 = G_2 + P_2G_1 + P_2P_1G_0 + P_2P_1P_0C_n \end{aligned}$ 

15,4,3	Function	P	G	Cn+4	ovr				
0	R+S	P3P2P1P0	G3 + P3G2 + P3P2G1 + P3P2P1G0	C4	C <sub>3</sub> <del>∨</del> C <sub>4</sub>				
1	S - R		Same as R + S equations, but sub	stitute Ri for Ri in definitio	ns.				
2	R-S		Same as R + S equations, but sub	stitute Si for Si in definition	ns.				
3	RVS	LOW	P3P2P1P0	P3P2P1P0 + Cn	P3P2P1P0 + Cn				
4	RAS	LOW	G3 + G2 + G1 + G0	G3 + G2 + G1 + G0 + Cn	G3 + G2 + G1 + G0 + Cn				
5	R٨S	LOW	Same as R $\overline{\Lambda}$ S equation	ns, but substitute $\overline{R_i}$ for $R_i$ i	n definitions.				
6	R₩S		Same as $\overline{R + S}$ equations, but substitute $\overline{R_i}$ for $R_i$ in definitions.						
7	R₩S	G3 + G2 + G1 + G0	G3 + P3G2 + P3P2G1 + P3P2P1G0	See Note 1	See Note 2				

Note 1:  $\overline{G_3 + P_3G_2 + P_3P_2G_1 + P_3P_2P_1P_0}(\overline{G_0} + \overline{C_n})$  Note 2:  $\overline{[P_2 + \overline{G_2P_1} + \overline{G_2G_1P_0} + \overline{G_2G_1G_0C_n}]} + \overline{[P_3 + \overline{G_3P_2} + \overline{G_3G_2P_1} + \overline{G_3G_2G_1P_0} + \overline{G_3G_2G_1G_0C_n}]}$  Figure 8. Logic Equations for Flag Outputs

#### Guaranteed Operating Conditions Over Temperature and Voltage for IDM2901A

When operated in a system, the timing requirements for the IDM2901 are defined in tables 1, 2, and 3. Table 1 provides clock characteristics of the IDM2901, table 2 gives the combinational delay times from input to output, and table 3 specifies setup and hold times. If used according to the specified delay and setup times, the device is guaranteed to function properly over the entire operating range. Table 3 defines the time prior to the end of the cycle (low-to-high transition of clock pulse) that each input must be stable to guarantee that the correct data is written into one of the internal registers.

Table 1. Cycle Time and Clock Characteristics

	IDM2901A		
Time	JC, NC	JM, JM/883	
Read-Modify-Write Cycle (time from selection of A,B registers to end of cycle)	60 ns	75 ns	
Maximum Clock Frequency to Shift Q Register (50% duty cycle)	16 MHz	16 MHz	
Minimum Clock Low Time	30 ns	30 ns	
Minimum Clock High Time	30 ns	30 ns	
Minimum Clock Period	60 ns	75 ns	

Table 2. Maximum Combinational Propagation Delays (all in ns; C ← ≤ 50 pF)

		IDN	12901A J	Comn C, NC (0		0°C;5V	± 5%)			Military IDM2901A JM, JM/883 (-55°C to +125°C; 5V ± 10%)						
To Output					F=0	T	Shift O	utputs	<u> </u>		1	l	F=0	1	Shift Outputs	
From Input	Y	F <sub>3</sub>	C <sub>n+4</sub>	Ğ/P	470	OVR	RAM <sub>0</sub> RAM <sub>3</sub>	Q <sub>0</sub>	Y	F3	C <sub>n+4</sub>	Ğ/P̄	470	OVR	RAM <sub>0</sub> RAM <sub>3</sub>	Q <sub>0</sub>
А, В	65	65	65	60	70	65	70	_	.80	80	80	65	85	80	80	-
D (arithmetic mode)	40	40	40	35	55	45	50	_	45	45	45	40	65	55	60	_
D (I = X37)	40	40	-	_	55	-	50	_	45	45	-	-	60	-	60	-
Cn	30 -	30	20	-	40	30	35	_	35	35	25	-	50	35	45	-
<sup>1</sup> 2,1,0	55	50	50	45	60	50	60		60	60	55	50	75	60	75	-
15,4,3	50	50	50	45	55	50	50		60	60	60	55	70	60	60	-
18,7,6	30	_	-	-	-	-	30	30	35	-	-	-	-	-	35	35
OE Enable/Disable	30/25	-	-	-	-	-	-	-	40/25	-	-	- T	-	-	-	_
A Bypassing ALU (I = 2xx)	40	-	-	-	-	-	-	-	50	-	-	-	-	_	-	-
Clock _ (Note 6)	60	60	60	50	60	55	60	30	65	65	65	55	75	70	75	35

Table 3. Maximum Setup and Hold Times (all in ns) - Note 1

•		Commercial IDM (0° C to +70° C		Military IDM2901A JM, JM/883 (-55°C to +125°C, 5V ± 10%)		
From Input	Notes	Setup Time	Hold Time	Setup Time	Hold Time	
A, B Source	2, 3, 4, 5	60, t <sub>pw</sub> L + 20	0	75, t <sub>pw</sub> L + 25	0	
B Destination	2, 4	t <sub>pw</sub> L + 15	0	t <sub>pw</sub> L + 15	0	
D (arithmetic mode)		40	0	50	0	
D (I = X37)	5	40	0	50	0	
Cn		35	0	40	0	
<sup>1</sup> 2,1,0		45	0	55	0	
15,4,3		45	0	55	0	
18,7,6	4	t <sub>pw</sub> L + 15	0	t <sub>pw</sub> L + 15	0	
RAM <sub>0.3</sub> /Q <sub>0.3</sub>		20	0	25	0	

Note 1: See figures 9 and 10.

Note 2: If the B address is used as a source operand, allow for the "A, B Source" setup time; if it is used only for the destination address, use the "B Destination" setup time.

Note 3: Where two numbers are shown, both must be met.

Note 4: "tpwL" is the clock low time.

Note 5: DVO is the fastest way to load the RAM from the D inputs. This function is obtained with I = X37.

Note 6: Using Q register as source operand in arithmetic mode. Clock is not normally in critical speed path when Q is not a source.

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#### Guaranteed Operating Conditions Over Temperature and Voltage for IDM2901A-1

When operated in a system, the timing requirements for the IDM2901A-1 are defined in tables 1, 2, and 3. Table 1 provides clock characteristics of the IDM2901A-1, table 2 gives the combinational delay times from input to output, and table 3 specifies setup and hold times. If used according to the specified delay and setup times, the device is guaranteed to function properly over the entire operating range. Table 3 defines the time prior to the end of the cycle (low-to-high transition of clock pulse) that each input must be stable to guarantee that the correct data is written into one of the internal registers.

Table 1. Cycle Time and Clock Characteristics

	IDM2	901A-1		
Time	JC, NC	JM, JM/883		
Read-Modify-Write Cycle (time from selection of A, B registers to end of cycle)	60 ns	75 ns		
Maximum Clock Frequency to Shift Q Register (50% duty cycle)	16 MHz	16 MHz		
Minimum Clock Low Time	30 ns	30 ns		
Minimum Clock High Time	30 ns	30 ns		
Minimum Clock Period	60 ns	75 ns		

Table 2. Maximum Combinational Propagation Delays (all in ns;  $C_L \le 50 \, pF$ )

		Commercial IDM2901A-1 JC, NC (0°C to +70°C; 5V ± 5%)							Military IDM2901A-1 JM, JM/883 (-55°C to +125°C; 5V ± 10%)							
To Output					F=0		Shift O	utputs			C <sub>n+4</sub>		F=0		Shift Outputs	
From Input	٧	F3	C <sub>n+4</sub>	G/P	RL = 470	OVR	RAM <sub>0</sub> RAM <sub>3</sub>	Ω <sub>0</sub> Ω <sub>3</sub>	Y	F3		G/P	R <sub>L</sub> = 470	OVR	RAM <sub>0</sub> RAM <sub>3</sub>	Q <sub>0</sub>
А, В	50	50	50	45	55	60	55	-	60	60	60	60	65	75	65	-
D (arithmetic mode)	32	32	32	30	32	40	35	_	40	40	40	40	40	50	45	-
D (I = X37)	32	32	_	-	32	-	35	-	40	40	-	-	40	_	45	-
Cn	25	22	16	-	30	25	35	-	32	30	20	-	40	35	45	T -
<sup>1</sup> 2,1,0	40	35	35	30	40	45	45	-	50	45	45	40	50	55	55	-
15,4,3	35	35	35	32	40	45	45.	-	45	45	45	40	50	55	55	-
18,7,6	25		_		-	-	30	30	35	_	_	-	-	_	35	35
OE Enable/Disable	20/20	-	-	-	-	-	-	-	25/25	_	-	-	-	-		-
A Bypassing ALU (I = 2xx)	40	-	_	-	-	-	-	-	50	_	-	-	-		-	-
Clock _ (Note 6)	50	45	45	40	50	55	55	30	60	55	55	50	60	65	65	35

Table 3. Maximum Setup and Hold Times (all in ns) - Note 1

		Commercial IDM2 (0°C to +70°C		Military IDM2901A-1 JM, JM/883 (-55°C to +125°C, 5V ± 10%)			
From Input	Notes	Setup Time	Hold Time	Setup Time	Hold Time		
A, B Source	2, 3, 4, 5	60, t <sub>pw</sub> L + 20	0	75, t <sub>pw</sub> L + 25	0		
B Destination	2, 4	t <sub>pw</sub> L + 15	0	t <sub>pw</sub> L + 15	0		
D (arithmetic mode)		40	0	50	0		
D (I = X37)	5	- 40	0	50	0		
C <sub>n</sub>		35	0	40	0		
<sup>1</sup> 2,1,0		45	0	55	0		
15,4,3		45	0	55	0		
<sup>1</sup> 8,7,6	4	t <sub>pw</sub> L + 15	0	t <sub>pw</sub> L + 15	0		
RAM <sub>0.3</sub> /Q <sub>0.3</sub>		15/10	0	25/15	0		

Note 1: See figures 9 and 10.

Note 2: If the B address is used as a source operand, allow for the "A, B Source" setup time; if it is used only for the destination address, use the "B Destination" setup time.

Note 3: Where two numbers are shown, both must be met.

Note 4: "tpwL" is the clock low time.

Note 5: DVO is the fastest way to load the RAM from the D inputs. This function is obtained with I = X37.

Note 6: Using Q register as source operand in arithmetic mode. Clock is not normally in critical speed path when Q is not a source.

#### Guaranteed Operating Conditions Over Temperature and Voltage for IDM2901A-2

When operated in a system, the timing requirements for the IDM2901A-2 are defined in tables 1, 2, and 3. Table 1 provides clock characteristics of the IDM2901A-2, table 2 gives the combinational delay times from input to output, and table 3 specifies setup and hold times. If used according to the specified delay and setup times, the device is guaranteed to function properly over the entire operating range. Table 3 defines the time prior to the end of the cycle (low-to-high transition of clock pulse) that each input must be stable to guarantee that the correct data is written into one of the internal registers.

**TABLE 1. Cycle Time and Clock Characteristics** 

	IDI	M2901A-2
Time	JC, NC	JM, JM/883
Read-Modify-Write Cycle (time from selection of A, B registers to end of cycle)	50 ns	65 ns
Maximum Clock Frequency to Shift Q Register (50% duty cycle)	20 MHz	16 MHz
Minimum Clock Low Time	25 ns	30 ns
Minimum Clock High Time	25 ns	30 ns
Minimum Clock Period	50 ns	65 ns

TABLE 2. Maximum Combinational Propagation Delays (all in ns; CL 50pF)

	IE	М290	1A-2 J		nmercia (0°C to		:; 5V ± 5	%)	Military IDM2901A-2 JM, JM/883 (-55°C to +125°C; 5V				V ± 10%			
to Output					F=0		Shift Outputs				}		F=0		Shift Outputs	
from Input	Y	F3	C <sub>n+4</sub>	G/P	R <sub>L</sub> = 470	OVR	RAM <sub>0</sub> RAM <sub>3</sub>		Y	F <sub>3</sub>	C <sub>n+4</sub>	G/P	R <sub>L</sub> = 470	OVR	RAM <sub>0</sub> RAM <sub>3</sub>	α <sub>0</sub>
A, B	44	44	44	35	44	45	40	_	55	50	50	45	55	55	50	_
D (arithmetic mode)	28	28	28	25	31	34	30	_	37	37	37	34	40	40	37	
D (I = X37)	28	28	-	_	31	_	30	-	37	37	_	-	40		37	_
C <sub>n</sub> .	25	22.	16		25	25	25	_	30	25	19	-	33	30	30	
12,1,0	35	35	35	28	35	39	35		45	45	45	45	45	45	40	-
15,4,3	35	35	35	32	35	35	35	-	45	40	40	40	45	45	40	
18,7,6	25		-	-	_	-	30	30.	30		-	_	_	-	35	35
OE Enable/Disable	20/20	_	-	_	_	_	_	-	25/25		-		_		_	
A Bypassing ALU (I = 2xx)	35	_	-	_	_	_	-	_	45	-	-	_	-	_	-	_
Clock (Note 6)	40	40	40	40	40	45	45	28	50	45	45	40	55	50	50	30

TABLE 3. Maximum Setup and Hold Times (all in ns) - Note 1

		Commercial IDM29 (0°C to +70°C,		Military IDM2901A-2 JM, JM/883 (-55°C to +125°C, 5V ± 10%)			
From Input	Notes	Setup Time	Hold Time	Setup Time	Hold Time		
A, B Source	2, 3, 4, 5	50, t <sub>pw</sub> L + 20	• о	60, t <sub>pw</sub> L + 20	0		
B Destination	2, 4	t <sub>pw</sub> L + 15	0	t <sub>pw</sub> L + 15	0		
D (arithmetic mode)		35	0	40	0		
D (I = X37)	5	35	0	40	0		
C <sub>n</sub>		26	0 .	30	0		
12,1,0		35	. 0	45	0		
15,4,3	r	30	0	45	0		
<sup>1</sup> 8,7,6	4	t <sub>pw</sub> L + 10	0	t <sub>pw</sub> L + 14	0		
RAM <sub>0.3</sub> /Q <sub>0.3</sub>		12/10	0	15/15	. 0		

Note 1: See figures 9 and 10.

Note 2: If the B address is used as a source operand, allow for the "A, B Source" setup time; if it is used only for the destination address, use the "B Destination" setup time.

Note 3: Where two numbers are shown, both must be met.

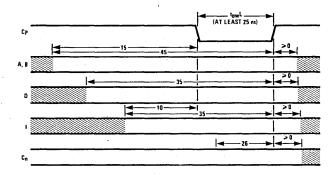
Note 4: "tpwL" is the clock low time.

Note 5: DVO is the fastest way to load the RAM from the D inputs. This function is obtained with I = X37.

Note 6: Using Q register as source operand in arithmetic mode. Clock is not normally in critical speed path when Q is not a source.

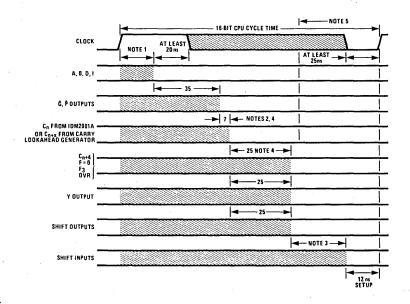
#### Set-Up and Hold Times (mimimum cycles from each input)

Setup and hold times are defined relative to the low-tohigh transition of the clock pulse. At all times, inputs must be stable from the setup time prior to the clock until the hold time after the clock — observe that all hold times are "zero." The set-up times allow sufficient time to perform the correct operation on the correct data so that the correct ALU data can be written into the correct register.



Note: Numbers shown are minimum data-stable times in nanoseconds for commercial product - see table 3 for detailed information,

Figure 9, Setup Times for Input Parameters of IDM2901



#### Notes:

- 1. This delay is the max  $t_{\mbox{\scriptsize pd}}$  of the register containing A, B, D, and I.
- 2. 7 ns for look-ahead carry. For ripple carry over 16 bits use 2 x (C  $_n \rightarrow \ C_{n+4}$ ), or 24 ns.
- 3. This is the delay associated with the multiplexer between the shift outputs and the shift inputs on the IDM2901.
- 4. Not applicable for logic operations.
- 5. Clock rising edge may occur here if add and shift do not occur on same cycle.

Figure 10. Switching Waveforms for 16-Bit System Assuming A, B, D, and I are Driven from Registers with the Same Propagation Delay and Clocked by the IDM2901. (These are maximum times in nanoseconds using commercial product specifications.)

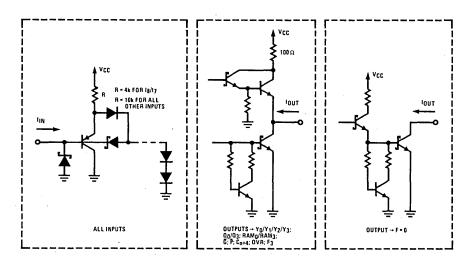


Figure 11. Equivalent Input/Output Current Interface Conditions for IDM2901

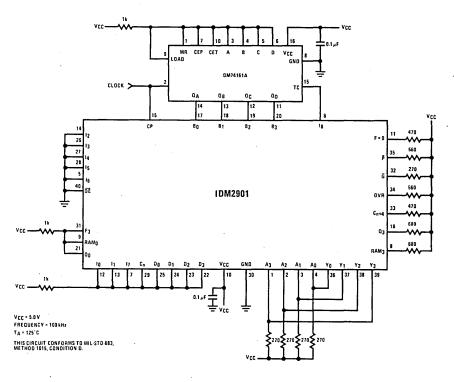
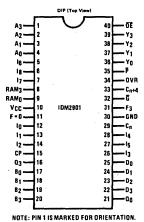


Figure 12. Burn-In Circuit for IDM2901

## **Connection Diagram**



### **Ordering Information**

Package Package Type Number		Temperature Range	Order Number					
Molded DIP	N40A	0°C to +70°C	IDM2901ANC/IDM2901A-1NC/IDM2901A-2NC					
Hermetic DIP	D40C	0°C to +70°C	IDM2901AJC/IDM2901A-1JC/IDM2901A-2JC					
Hermetic DIP	D40C	-55°C to +125°C	IDM2901AJM/IDM2901A-1JM/IDM2901A-2JM					
Hermetic DIP	D40C -	-55°C to +125°C	IDM2901AJM/883/IDM2901A-1JM/883/IDM2901A-2JM/883					



## 2900 Family/ Bipolar Microprocessor

### **IDM2902** Look-Ahead Carry Generator

#### **General Description**

This circuit is a high-speed, look-ahead carry generator, capable of anticipating a carry across four binary adders or groups of adders. It is cascadable to perform full look-ahead across n-bit adders. Carry, generate-carry, and propagate-carry functions are provided as shown in the pin designation table.

When used in conjunction with the IDM2901A arithmetic logic units, this generator provides high-speed carry look-ahead capability for any word length. The IDM2902 generates the look-ahead (anticipated carry) across a group of four ALUs and, in addition, other carry look-ahead circuits may be employed to anticipate carry across sections of four look-ahead packages up to n bits. The method of cascading circuits to perform multi-level look-ahead is illustrated under typical application data.

Carry input and output of the ALUs are in their true form, and the carry propagate (P) and carry generate (G) are in negated form; therefore, the carry functions (inputs, outputs, generate, and propagate) of the look-

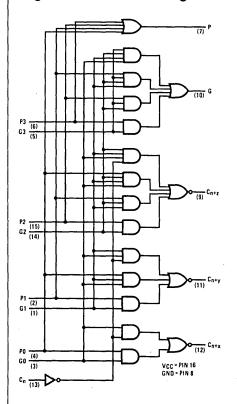
ahead generators are implemented in the compatible forms for direct connection to the ALU. Reinterpretations of carry functions, as explained on the IDM2901A data sheet, are also applicable to and compatible with the look-ahead generator. Positive logic equations for the 2902 parts are:

$$\begin{split} & C_{n+x} = G_0 + P_0 C_n \\ & C_{n+y} = G_1 + P_1 G_0 + P_1 P_0 C_n \\ & C_{n+z} = G_2 + P_2 G_1 + P_2 P_1 G_0 + P_2 P_1 P_0 C_n \\ & G = G_3 (P_3 + G_2) (P_3 + P_2 + G_1) (P_3 + P_2 + P_1 + G_0) \\ & P = P_3 P_2 P_1 P_0 \end{split}$$

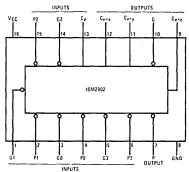
#### Features and Benefits

Туре	Typical Propagation Delay Time	Typical Power Dissipation
IDM2902	7 ns	260 mW

#### Logic and Connection Diagram



#### Connection Diagram



### Pin Designations

Designation	Pin Nos.	Function			
G <sub>0</sub> , G <sub>1</sub> , G <sub>2</sub> , G <sub>3</sub>	3, 1, 14, 5	Active Low Carry Generate Inputs			
P <sub>0</sub> , P <sub>1</sub> , P <sub>2</sub> , P <sub>3</sub>	4, 2, 15, 6	Active Low Carry Propagate Inputs			
Cn	13	Carry Input			
C <sub>n+x</sub> , C <sub>n+y</sub> , C <sub>n+z</sub>	12, 11, 9	Carry Outputs			
G	10	Active Low Carry Generate Output			
P	7	Active Low Carry Propagate Output			
VCC	16	Supply Voltage			
GND	8	Ground			

#### **Absolute Maximum Ratings**

Temperature (Ambient) Under Bias

Supply Voltage to Ground Potential

DC Voltage Applied to Outputs for

DC Output Current, into Outputs

Storage Temperature

High Output State

DC Input Voltage

DC Input Current

-65°C to +150°C -55°C to +125°C -0.5V to +6.3V

-0.5V to +VCC max -0.5V to +5.5V

30 mA -30 mA to +5.0 mA

### **Operating Range**

P/N

IDM2902JM, JM/883

IDM2902JC, NC

Ambient Temperature

Vcc

 $0^{\circ}$ C to  $+70^{\circ}$ C 4.75V to 5.25V -55°C to +125°C 4.50V to 5.50V

#### Electrical Characteristics Over Operating Temperature Range (unless otherwise noted)

Commercial

 $T_A = 0^{\circ}C$  to  $+70^{\circ}C$ 

 $V_{CC} = 5.0 V \pm 5\%$ 

MIN = 4.75 V

MAX = 5.25V

Military

 $T_A = -55^{\circ}C \text{ to } +125^{\circ}C$   $V_{CC} = 5.0 \text{V} \pm 10\%$ 

MIN = 4.50V

MAX = 5.50V

Parameter	Description	Test Conditions (Not	e 1)	Min.	Typ. (Note 2)	Max.	Units	
Voн	Output HIGH Voltage	V <sub>CC</sub> = MIN, I <sub>OH</sub> = -0.8 mA			3.4		v	
VOL	Output LOW Voltage	V <sub>CC</sub> = MIN, I <sub>OL</sub> = 16 mA V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>			,	0.5	v	
VIH	Input HIGH Level	Guaranteed input logical HIGH voltage for all inputs	1	2.0			V <sub>.</sub>	
VIL	Input LOW Level	Guaranteed input logical LOW voltage for all inputs				0.8	٧	
٧ı	Input Clamp Voltage	V <sub>CC</sub> = MIN, I <sub>IN</sub> = -12 mA				-1.5	v.	
			Cn			-2		
	·	·	P <sub>3</sub>			-4		
IIL I	Input LOW Current	VCC = MAX, VIN = 0.5V	P <sub>2</sub>			-6 ·	mA	
Note 3)	input LOW Current	ACC = MAY, AIM = 0.9 A	P <sub>0</sub> , P <sub>1</sub> , G <sub>3</sub>			-8.0	mA	
			G <sub>0</sub> , G <sub>2</sub>			-14		
			G <sub>1</sub>			-16		
			Cn			50		
			P <sub>3</sub>			100		
чн		N	P2.	1		150	μΑ	
(Note 3)	Input HIGH Current	V <sub>CC</sub> = MAX, V <sub>IN</sub> = 2.7V	P <sub>0</sub> , P <sub>1</sub> , G <sub>3</sub>			200		
			G <sub>0</sub> , G <sub>2</sub>			350		
			G <sub>1</sub>	1		400		
Ц	Input HIGH Current	VCC = MAX, VIN = 5.5V				1.0	mA	
Isc	Output Short Circuit (Note 4)	VCC = MAX, VOUT = 0.0V		-40		-100	mA	
		VCC = MAX	MIL		62	99		
		All Outputs LOW	COM'L		58	94	mA	
Icc	Power Supply Current	Vcc = MAX	MIL		37			
·		All Outputs HIGH	COM'L		35		mA	

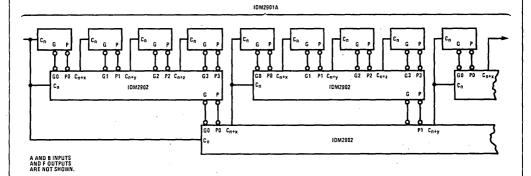
- 1. For conditions shown as MIN or MAX, use the appropriate value specified under Electrical Characteristics for the applicable device type.
- 2. Typical limits are at  $V_{CC}$  = 5.0 V, 25° C ambient and maximum loading.
- 3. Actual input currents = Unit Load Current times Input Load Factor (see Loading Rules).
- 4. Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.

### Switching Characteristics $V_{CC}$ = 5.0 V, $T_A$ = 25°C, $C_L$ = 15 pF, $R_L$ = 400 $\Omega$

Parameter	From (Input)	To (Output)	Test Conditions	Min.	Тур.	Max.	Units
<sup>t</sup> PLH			P <sub>0</sub> = P <sub>1</sub> = P <sub>2</sub> = 0V		9.0	12	
†PHL	C <sub>n</sub>	C <sub>n+j</sub>	$G_0 = G_1 = G_2 = 4.5 \text{V}$		9.0	12	ns
tPLH	D.		$P_i = 0 \vee (j > i)$		6.0	8.0	
tPHL.	Pi	C <sub>n+j</sub>	$C_n = G_0 = G_1 = G_2 = 4.5V$		6.0	8.0	ns
tPLH	C.		$G_i = 0 \vee (j > i)$		7.0	10	
tPHL.	Gi	C <sub>n+j</sub>	$C_n = P_0 = P_1 = P_2 = 4.5 V$		7.0	10	- ns
tPLH		0.0	$P_i = 0 \lor (j > i)$		6.0	10	
tPHL.	Pi	G or P	$C_n = G_0 = G_1 = G_2 = 4.5 \text{V}$		6.0	10	ns
tPLH		C D	$G_i = 0 \vee (j > i)$		7.0	10	
†PHL	Gi	GorP	$C_n = P_0 = P_1 = P_2 = 4.5V$		7.0	10	ns

### **Typical Application**

64-Bit ALU with Full Look-Ahead Carry in Three Levels



### **Ordering Information**

Package Type	Package Number	Temperature Range	Order Number
Molded DIP	N16A	0°C to +70°C	IDM2902NC/DM74S182N
Hermetic DIP	J16A (D16C)	0°C to +70°C	IDM2902JC/DM74S182J
Hermetic DIP	J16A (D16C)	-55°C to +125°C	IDM2902JM/DM54S182J
Hermetic DIP	J16A (D16C)	-55°C to +125°C	IDM2902JM/883/DM54S182J/883



## 2900 Family/ Bipolar Microprocessor

## IDM2909A/11A Microprogram Sequencer

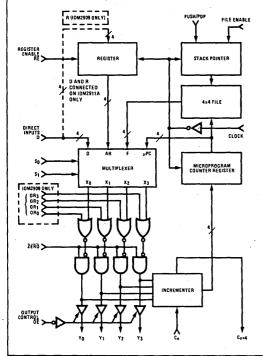
#### **General Description**

The IDM2909A is a 4-bit wide address controller that is used to sequence through a series of microinstructions contained in ROM or PROM. Two devices can be interconnected to generate an 8-bit address (256 words), three devices for a 12-bit address (4k words), and so on. For a given device, the 4-bit address field can originate from any one of four sources. These are: (1) direct "D" inputs from an external source, (2) external data from an internal register "R," (3) a push/pop stack that is 4 words deep, and (4) a program counter, which usually contains the last address incremented by "1." Control of the push/pop stack is such that the stack can efficiently execute nested subroutine linkages. Moreover, each of the four TRI-STATE outputs can be ORed with an external input to implement conditional skips or branch instructions; a separate line is used to force the outputs to an "all-zero" state. As shown in the block diagram, the IDM2911A is identical to the IDM2909A, except the four OR inputs are removed and the "D" and "R" inputs are connected. The IDM2909A is housed in a 28-pin dual-in-line package, whereas the IDM2911A is a 20-pin device.

#### Features and Benefits

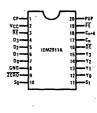
- 4-bit cascadable slice any number of microwords can be generated.
- Internal address register provides four address sources.
- Branch input for N-way branches where "N" is any word in the microcode.
- Cascadable 4-bit microprogram counter.
- 4x4 file with stack pointer and push/pop control four microsubroutines can be nested.
- Zero input for returning to microcode word "zero."
- Individual OR input for each bit to branch to higher microinstruction (IDM2909A only).
- TRI-STATE outputs.
- All internal registers change state on Low-to-High transition of clock pulse.

#### Simplified Block Diagram



#### **Connection Diagrams**





### **Absolute Maximum Ratings**

Storage Temperature -65°C to +150°C
Temperature (Ambient) Under Bias -55°C to +125°C
Supply Voltage to Ground Potential Continuous
DC Voltage Applied to Outputs for
High Output State
DC Input Voltage -0.5V to +7.0V
DC Output Current into Outputs -30 mA
DC Input Current -30 mA to +5.0 mA

#### **Operating Range**

P/N	Ambient Temperature	Vcc
IDM2909ANC, JC	0°C to +70°C	4.75V to 5.25V
IDM2911ANC, JC	$0^{\circ}$ C to $+70^{\circ}$ C	4.75V to 5.25V
IDM2909AJM, JM/883	-55°C to +125°C	
IDM2911AJM, JM/883	-55°C to +125°C	4.50V to 5.50V

#### **Electrical Characteristics**

Commercial  $T_A = 0^{\circ}C$  to +70°C,  $V_{CC} = 4.75V$  to 5.25V Military  $T_A = -55^{\circ}C$  to +125°C,  $V_{CC} = 4.50V$  to 5.50V

Parameter	Description	Test Cond	itions (N	Note 1)	Min.	Typ. (Note 2)	Max.	Units
VOH	Output High Voltage	V <sub>CC</sub> = min,	Mil	IOH = -1.0 mA	2.4			V
		VIN = VIH or VIL	Com'l	I <sub>OH</sub> = -2.6 mA	2.4			
V <sub>OL</sub> O	Output Low Voltage	VIN = VIH or VIL	I <sub>OL</sub> = 4.0 mA				0.4	V
			I <sub>OL</sub> = 8.0 mA				0.45	
			lor =	16 mA (Note 5)		0.5		,
VIH	Input High Level	Guaranteed input lo	logical high voltage for all		2.0			٧
VIL	Input Low Level	Guaranteed input lo	Guaranteed input logical low voltage for all inputs				0.8	٧
VI	Input Clamp Voltage	V <sub>CC</sub> = min, I <sub>IN</sub> = -18 mA		-		-1.5	٧	
IJĽ	Input Low Current	V <sub>CC</sub> = max, V <sub>IN</sub> = 0.4 V				-0.36	mA	
lін	Input High Current	V <sub>CC</sub> = max, V <sub>IN</sub> = 2.7 V				20	μΑ	
I <sub>I</sub>	Input High Current	V <sub>CC</sub> = max, V <sub>IN</sub> = 7.0V				0.1	mA	
los	Output Short Circuit Current (Note 3)	V <sub>CC</sub> = max		-40		-100	mA	
¹cc	Power Supply Current	V <sub>CC</sub> = max (Note 4)			80	130	mA	
lozL	Output Off Current	VCC = max,	Vout	= 0.4 V			-20	μΑ
lozh		OE = 2.7 V	Vout	· = 2.7 V			20	

#### Notes:

- 1. For conditions shown as MIN or MAX, use the appropriate value specified under Electrical Characteristics for the applicable device type.
- 2. Typical limits are at V<sub>CC</sub> = 5.0 V, 25° C ambient and maximum loading.
- 3. Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.
- Apply GND to C<sub>n</sub>, R<sub>0</sub>, R<sub>1</sub>, R<sub>2</sub>, R<sub>3</sub>, OR<sub>0</sub>, OR<sub>1</sub>, OR<sub>2</sub>, OR<sub>3</sub>, D<sub>0</sub>, D<sub>1</sub>, D<sub>2</sub>, and D<sub>3</sub>. Other inputs open. All outputs open. Measured after a LOW-to-HIGH clock transition.
- 5. The 16 mA guarantee applies only to  $Y_0$ ,  $Y_1$ ,  $Y_2$ , and  $Y_3$ .

### Standard Screening (Conforms to MIL-STD-883 for Class C Parts)

	MIL-STD-883	1	Level			
Step	Method	Conditions	IDM2909A/2911A NC, JC	IDM2909A/2911A JM		
Pre-Seal Visual Inspection	2010	В	100%	100%		
Stabilization Bake	1008	C 24-hour, 150°C	100%	100%		
Temperature Cycle	1010	C -65°C to +150°C 10 cycles	100%	100%		
Centrifuge	2001	B 10,000 G	100%*	100%		
Fine Leak	1014	A 5 x 10 <sup>-8</sup> atm-cc/cm <sup>3</sup>	100%*	100%		
Gross Leak	1014	C Fluorocarbon	100%*	100%		
Electrical Test Subgroups 1, 7, and 9	5004	See below for definitions of subgroups	100%	100%		
Insert Additional Screening	here for Class B	Parts				
Group A Sample Tests Subgroup 1 Subgroup 2 Subgroup 3 Subgroup 7 Subgroup 8 Subgroup 9	5005	See below for definitions of subgroups	LTPD = 5 LTPD = 7 LTPD = 7 LTPD = 7 LTPD = 7 LTPD = 7	LTPD = 5 LTPD = 7 LTPD = 7 LTPD = 5 LTPD = 7 LTPD = 5		

<sup>\*</sup>Not applicable to IDM2909ANC or IDM2911ANC.

Group A Subgroups (as defined in MIL-STD-883, Method 5005)

Subgroup	Parameter	Temperature
1	DC	25°C
2	DC.	Maximum Rated Temperature
3	DC	Minimum Rated Temperature
7	Function	25°C
8	Function	Maximum and Minimum Rated Temperature
9	Switching	25°C
10	Switching	Maximum Rated Temperature
11	Switching	Minimum Rated Temperature

#### Additional Screening for Class B Parts

Step	MIL-STD-883 Method	Conditions	Level IDM2909A/11A JM/883
Burn-In	1015	D 125°C 160 hours min.	100%
Electrical Test	5004		
Subgroup 1		. "	100%
Subgroup 2			100%
Subgroup 3			100%
Subgroup 7			100%
Subgroup 9	- "		100%

### **Switching Characteristics Over Operating Range**

All parameters are guaranteed worst case over the operating voltage and temperature range for the device type.

IDM2909A/11A JC, NC

 $T_{\Delta} = 0^{\circ}C \text{ to } +70^{\circ}C$ 

 $V_{CC} = 4.75 V$  to 5.25 V

IDM2909A/11A JM, JM/883

 $T_A = -55^{\circ}C \text{ to } +125^{\circ}C \qquad V_{CC} = 4.5 \text{V to } 5.5 \text{V}$ 

Table 1. Minimum Clock Requirements

Minimum Clock Low Time	30
Minimum Clock High Time	30

Table 2.

Maximum Combinatorial Propagation Delays

	Outputs			
Inputs	Yi	Cn+4		
ŌĒ	25	_		
ZERO	30	35		
ORi	20	30		
S <sub>0</sub> , S <sub>1</sub>	30	35		
Di	20	30		
Cn		18		

Table 3. Maximum Delays from Clock to Outputs

Functional Path	Grade	Clock to Yi	Clock to C <sub>n+4</sub>
Register <sub>.</sub>	С	40	45
(S <sub>1</sub> S <sub>0</sub> = LH)	М	50	55
μ Program Counter	С	40	45
(S <sub>1</sub> S <sub>0</sub> = LL)	М	50	55
File	С	45	50
(S <sub>1</sub> S <sub>0</sub> = HL)	М	55	60

CL≤ 50pF (except output disable tests)

Table 4. Setup and Hold Time Requirements

External Inputs	ts	th
RE	20	0
Ri	15	0
PUSH/POP	20	0
FE	20	0
Cn	15	0
Di	20	0
ORi	20	0
S <sub>0</sub> , S <sub>1</sub>	30	0
ZERO	30	0

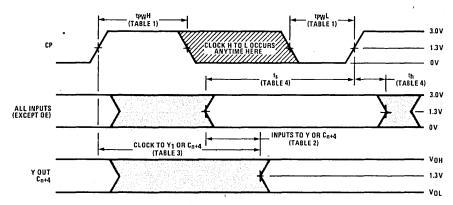


Figure 1. Switching Waveforms (refer to preceding tables for specific values)

# Architecture of Microprogram Sequencer

A 4-input multiplexer selects one of four sources for the address of the next microinstruction address; these sources are: the address register, the microprogram counter, direct inputs, and the memory file. The multiplexer is controlled by the S0/S1 inputs. As shown in figure 2, the address register consists of four D-type edge-triggered flip-flops with a common clock enable. When the REGISTER ENABLE signal is low, new data is entered on the low-to-high transition of the clock. The "Q" outputs of the address register are available at the input of the multiplexer as a source for the next microinstruction address. The direct inputs (D0-D3) can likewise be selected as an address input to the multiplexer.

Both the IDM2909A and the IDM2911A are bipolar microprogram sequencers designed for use in high-speed

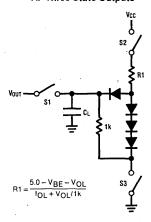
microprocessors, high-performance computer control units, and other applications where overlap fetch of the microinstruction is required. Each device is cascadable in 4-bit increments such that two devices can address up to 256 words of microprogram memory, three devices up to 4k of memory, and so on. A detailed block diagram of the microprogram sequencer is shown in figure 2.

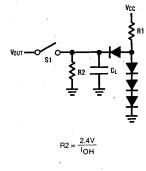
In the IDM2911A, the 4-bit direct field is also used as an input to the address register, that is, R0 and D0 are connected, R1 and D1 are connected, and so on. With the "R" and "D" connections made and the OR inputs removed, the IDM2911A can perform an N-way branch, where "N" is any word in the microcode.

# Test Output Load Configurations for IDM2909A/2911A

#### A. Three-State Outputs

### **B. Normal Outputs**





 $R1 = \frac{5.0 - V_{BE} - V_{OL}}{I_{OL} + V_{OL}/R2}$ 

Note 1:  $C_L = 50$  pF includes scope probe, wiring and stray capacitances without device in test fixture.

Note 2: S1, S2, S3 are closed during function tests and all AC tests except output enable tests.

Note 3: S1 and S3 are closed while S2 is open for tpzH test. S1 and S2 are closed while S3 is open for tpzL test.

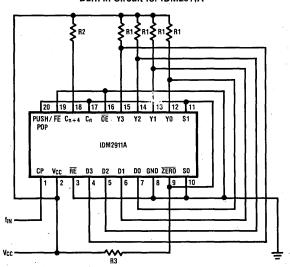
Note 4:  $C_L = 5.0$  pF for output disable tests.

# **Test Output Loads**

Pin #	Pin Label	Test	IDM	2909	1DM2	2909A
(DIP)	PIII Labei	Circuit	R1	R2	R1	R2
18-21	Y <sub>0-3</sub>	Α	300	1k	220	1k
24	C <sub>n+4</sub>	• В	470	2.4k	220	2.4k

Pin #	Pin Label	Test	IDM	2911	IDM	2911A
(DIP)	Pin Laber	Circuit	R1	R2	R1	R2
12-15	Y <sub>0-3</sub> ,	Α	300	1k	220	1k
18	C <sub>n+4</sub>	В	470	2.4k	220	2.4k

#### **Burn in Circuit for IDM2911A**



Notes:  $Max I_{CC} = 200 \text{ mA}$  $T_A = + 125 ^{\circ}\text{C}$ 

 $\begin{aligned} & \text{Resistors} = \pm \, 5\% \\ & \text{R1} = 390 \Omega \end{aligned}$ 

 $\text{R2} = 560\Omega$ 

 $R3 = 1 k\Omega$ 

f<sub>IN</sub> = 100 kHz, 50% duty cycle, 0V-3V From clock buffer on each board:

 $V_{CC}$  min = 5.0V  $V_{CC}$  max = 5.1V

The microprogram counter consists of a 4-bit incrementer followed by a 4-bit register. The carry-in (Cn) and carry-out (Cn+4) features of the incrementer make cascading to larger word lengths easy and straightforward. The microprogram counter can be used in either of two ways. When the least significant bit of Cn is high, the microprogram register (µPC) is loaded on the next clock cycle with the current output word (Y0-Y3) plus 1, that is,  $Y + 1 \rightarrow \mu PC$ ; thus, sequential microinstructions are executed. When  $C_n$  is low, the "Y" outputs are not incremented; accordingly, the same microinstruction can be repeatedly executed. The last address source available at the input of the multiplexer is the 4-bit/4-word stack file; when executing subroutines, the file provides return address linkage. The 4-by-4 memory matrix contains a stack pointer (SP) that always points to the last word written in the file; thus, stack reference operations (looping) can be performed without a push or pop. The stack pointer operates as an up/down counter with separate PUSH/POP and FILE ENABLE inputs. When the enable signal is low and the other signal is high, the "push" operation is enabled. Under these conditions, the stack pointer is incremented and the file is written with the required return linkage, that is, the next microinstruction address following the subroutine jump that initiated the "push." If both input signals (PUSH/POP and FILE ENABLE) are low, a "pop" operation is implemented. During this clock cycle, the return linkage is used to return from the subroutine; the next low-tohigh transition of the clock pulse decrements the stack

When the FILE ENABLE signal is high, the stack pointer is not incremented or decremented, regardless of whether the PUSH/POP signal is high or low. Linkage of the stack pointer is such that any combination of pushes, pops, or stack references can be implemented; one microinstruction subroutine can be performed. Since the stack is 4 words deep, up to four microsubroutines can be nested. The ZERO input is used to force all four outputs ( $\gamma_0-\gamma_3$ ) of the multiplexer to the zero (logic 0) state. When the zero input is low, all Y-outputs are low, unless overridden by the OUTPUT ENABLE ( $\overline{\text{OE}}$ ) signal. Also, each bit of the Y-output word can be ORed at the input such that conditional logic can be enforced; this allows execution of microinstructions to occur in any programmed sequence.

# Definition of Terms and Symbols (Figure 2)

#### Inputs to IDM2909A/11A:

S <sub>0</sub> /S <sub>1</sub>	Control lines for address-source selection
FE/PUP	Control lines for push/pop stack
RE	Enable signal for internal address register
ORi	Logic OR input for each address output line
ZERO	Logic AND input for all output lines
ŌĒ	Output Enable; when $\overline{\text{OE}}$ is high, the Y-outputs are TRI-STATE (high impedance)
Cn	Carry-in to incrementer
$R_i$	Inputs to the internal address register
Di	Direct inputs to the multiplexer
CP .	Clock inputs

#### Outputs from the IDM2909A/11A:

Yi	Address outputs; address inputs to control memory
Cn+4	Carry-out from the incrementer

μPC Contents of the microprogram counter

REG Contents of the internal register STK0/STK3 Contents of the push/pop stack. By

definition, the word addressed by the stack pointer in the 4-by-4 file is STKO. Data is pushed onto the stack at STKO and is subsequently pushed to STK1, STK2, and finally to STK3. When the stack is popped, data is removed in the following order: STK3 -> STK2 -> STK1, and then to STKO. When a push or pop occurs, only the stack pointer changes -- the data is not physically shifted within the stack.

Contents of the stack pointer

#### Terms and symbols external to the IDM2909A/11A:

A Control memory address

I(A) Instruction in control memory at address "A"

μWR Contents of microword register at output of control memory; this register

contains the instruction currently being executed

T<sub>n</sub> Period of timing cycle

# Operation of the IDM2909A/11A

SP

Select codes for the multiplexer and the truth tables for output control/stack control are shown in figure 3. The two bits (S<sub>0</sub>/S<sub>1</sub>) from the microword register (plus additional branching logic) determine the data source for the next microinstruction address. The selected data source appears on the Y-outputs of the multiplexer.

A state table for S<sub>0</sub>, S<sub>1</sub>, FE, and PUP is shown in figure 4; these signals define not only the address specified by the Y-outputs, but also the state of all internal registers, following the low-to-high transition of the clock pulse. In figure 4, it is assumed that the microprogram counter initially contains some word "J," word "K" is in the address register, and words  $R_a$  through  $R_d$  are contained in the 4-word push/pop stack.

The sequence for executing a subroutine using the IDM2909A is illustrated in figure 5. For any given clock cycle, the instruction being executed is contained in the microword register (µWR); the contents of this register also directly (or indirectly) control So, S1, FE, and PUP. At the appropriate time, the starting address of the subroutine is applied to the "D" inputs of the sequencer. The three left-hand columns of figure 5 show the execution sequence of the instructions and the designated execution cycles. At address "J+2," the sequencecontrol part of the microinstruction contains the command "Jump To Subroutine A." At time t2, the "J+2" instruction resides in the µWR and the inputs of the sequencer are set up to execute the "jump," and to save the return address. Address bits for subroutine "A" are taken from the microword register and applied to the D-inputs of the multiplexer; the output appears at the Y-port of the multiplexer.

#### Address Selection

Octal	S <sub>1</sub>	s <sub>0</sub>	Source for Y Outputs	Symbol
0	L	L	Microprogram Counter	μРС
1	L	Н	Register	REG
2	H	L	Push-Pop Stack	STK0
3	Н	Н	Direct Inputs	Di

ORi	ZERO	ŌĒ	Yi
Х	Х	н	Z
X	L	L	L
Н	Н	L	н .
L	Н	L	Source selected by SoS1

Z = High Impedance

#### Synchronous Stack Control

FE	PUP	Push-Pop Stack Change
Н	X	No change
L	Н	Increment stack pointer, then push current PC onto STK0
L	L	Pop stack (decrement stack pointer)

H = High

L = Low

X = Don't Care

Figure 3. Truth Tables for Multiplexer Control Signals

						,				
Cycle	S <sub>1</sub> , S <sub>0</sub> , FE, PUP	μРС	REG	<b>STKO</b>	STK1	STK2	<b>STK3</b>	Youт	Comment	Principal Use
N N+1	0 0 0 0	J J+1	K K	Ra Rb	R <sub>b</sub> R <sub>c</sub>	R <sub>c</sub> R <sub>d</sub>	R <sub>d</sub> R <sub>a</sub>	J	Pop Stack	End Loop
N N+1	0 0 0 1	J J+1	K K	R <sub>a</sub> J	Rb. Ra	R <sub>c</sub> R <sub>b</sub>	Rd . Rc	_ J	Push μPC	Set Up Loop
N N+1	0 0 1 X	J J+1	K K	R <sub>a</sub> R <sub>a</sub>	Rb Rb	R <sub>c</sub> R <sub>c</sub>	Rd Rd	_ 1	Continue	Continue
N N+1	0 1 0 0	J K+1	K K	R <sub>a</sub> Rb	Rb Rc	Rc Rd	Rd Ra	K -	Pop Stack; Use AR for Address	End Loop
N N+1	0 1 0 1	J K+1	K K	R <sub>a</sub> J	Rb Ra	R <sub>c</sub> Rb	R <sub>d</sub> R <sub>c</sub>	K -	Push μPC; Jump to Address in AR	JSR AR
N N+1	0 1 1 X -	J K+1	K K	R <sub>a</sub> R <sub>a</sub>	Rb Rb	R <sub>c</sub> R <sub>c</sub>	Rd Rd	K -	Jump to Address in AR	JMP AR
N N+1	1 0 0 0	J Ra+1	K K	R <sub>a</sub> Rb	Rb Rc	R <sub>c</sub> Rd	Rd Ra	R <sub>a</sub>	Jump to Address in STK0; Pop Stack	RTS
N N+1	1 0 0 1	J Ra+1	K K	R <sub>a</sub> J	Rb Ra	R <sub>C</sub> Rb	R <sub>d</sub> R <sub>c</sub>	R <sub>a</sub>	Jump to Address in STK0; Push µPC	
N N+1	1 0 1 X	J Ra+1	K K	R <sub>a</sub> R <sub>a</sub>	Rb Rb	R <sub>C</sub> R <sub>C</sub>	Rd Rd	Ra .	Jump to Address in STK0	Stack Ref (Loop)
N N+1	1 1 0 0	J D+1	K K	R <sub>a</sub> R <sub>b</sub>	R <sub>b</sub> R <sub>c</sub>	R <sub>c</sub> R <sub>d</sub>	Rd Ra	D -	Pop Stack; Jump to Address on D	End Loop
N N+1	1 1 0 1	J D+1	K K	R <sub>a</sub> J	Rb Ra	R <sub>C</sub> R <sub>b</sub>	Rd Rc	D -	Jump to Address on D; Push µPC	JSR D
N N+1	1 1 1 X -	J D+1	K K	R <sub>a</sub> R <sub>a</sub>	Rb Rb	R <sub>c</sub> R <sub>c</sub>	Rd Rd	D -	Jump to Address on D	JMP D

X = Don't Care, 0 = Low, 1 = High, Assume C<sub>n</sub> = High

Note: STKO is the location addressed by the stack pointer.

Figure 4. Output and Internal Next-Cycle Register States for IDM2909A/11A

#### **Control Memory**

Execute	Micro	program
Cycle	Address	Sequencer Instruction
	J-1	_
t <sub>0</sub>	J	<b> </b>
t1 '	J+1	-
t2	J+2	JSR A
t <sub>6</sub>	J+3	-
t7	J+4	-
	_	l –
	_	-
	_	-
	-	-
	-	i –
tg	Α	I(A)
t4	A+1	_
t5	A+2	RTS
	_	_
	-	[ -
		-
	_	_
	-	-
	_	- "
	_	-

Execute C	ycle	to	t <sub>1</sub>	t <sub>2</sub>	t3	t4	t <sub>5</sub>	t <sub>6</sub>	t7	t8	t9
CI	ock	П									
Signal	s `				_			-			
IDM2909A Inputs (from µWR)	S <sub>1</sub> , S <sub>0</sub> FE PUP D	0 H X X	0 H X X	3 L H A	0 H X X	0 H X X	2 L L X	0 Н Х	0 H X		
Internal Registers	μPC STK0 STK1 STK2 STK3	J+1  - -	J+2 - - -	J+3 - - -	A+1 J+3 - -	A+2 J+3 - -	A+3 J+3  -	J+4 - - -	J+5 - - -		
IDM2909A Output	Υ .	J+1	J+2	Α	A+1	A+2	J+3	J+4	J+5		
ROM Output	(Y)	I(J+1)	JSR A	I(A)	I(A+1)	RTS	I (J+3)	I (J+4)	I (J+5)		
Contents of µWR (Instruction being executed)	μWR	1(1)	I(J+1)	JSR A	I(A)	I(A+1)	RTS	I (J+3)	I(J+4)		

Figure 5. Execution of Subroutine

Subsequently, the first instruction "I(A)" of the subroutine is accessed and input to  $\mu$ WR. On the next low-to-high transition of the clock, I(A) is loaded into  $\mu$ WR for execution and the return address (J+3) is pushed onto

the stack. At t5, the return instruction is executed. Figure 6 shows a similar instruction sequence where one subroutine is linked to another — the second subroutine consists of only one microinstruction.

### **Control Memory**

Execute	Micro	program
Cycle	Address	Sequencer Instruction
	J-1	-
t <sub>O</sub>	J	- 1
t1	J+1	
t2	J+2	JSR A
tg .	J+3	_
1	-	_
	-	-
	-	
}	-	
t <sub>3</sub>	Α	
-t4	A+1	-
t <sub>5</sub>	A+2	JSR B
t7	A+3	-
tg	A+4	RTS
ļ	-	-
	_	_
	_ '	-
!	_ '	-
t <sub>6</sub>	В	RTS
_		_
		-

Execute Cy	/cle	to	<b>t</b> 1	t2	t3	<b>t</b> 4	t5	t6	t7	t8	tg
CI	ock										
Signal							1		ĺ		
IDM2909A Inputs (from µWR)	S <sub>1</sub> , S <sub>0</sub> FE PUP D	0 H X X	0 H X X	3 L H A	0 H X X	0 H X X	3 L H B	2 L L X	0 H X X	2 L L X	0 H X X
Internal Registers	μPC STK0 STK1 STK2 STK3	J+1 - - -	J+2 - - -	J+3   	A+1 J+3 - -	A+2 J+3  -	A+3 J+3 - -	B+1 A+3 J+3 -	A+4 J+3 - -	A+5 J+3  	J+4   -
IDM2909A Output	Y	J+1	J+2	Α	A+1	A+2	В	A+3	A+4	J+3	J+4
ROM Output	(Y)	I(J+1)	JSR A	I(A)	I(A+1)	JSR B	RTS	I(A+3)	RTS	I(J+3)	I(J+4)
Contents of µWR (Instruction being executed)	μWR	1(J)	I(J+1)	JSR A	I(A)	I(A+1)	JSR B	RTS	I(A+3)	RTS	I(J+3)

Figure 6. Two Nested Subroutines

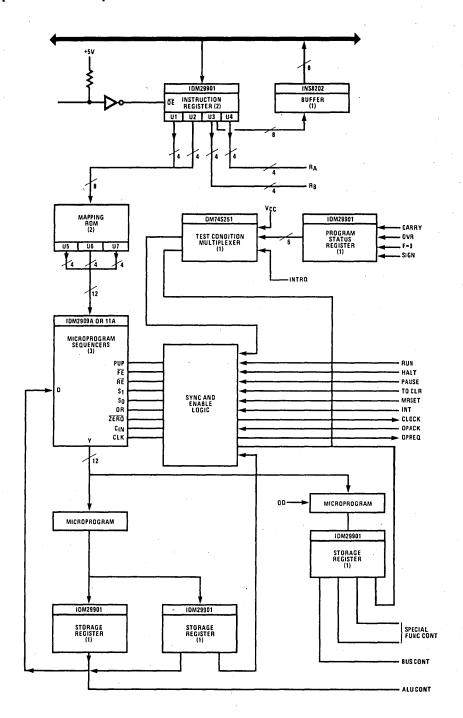


Figure 7. Typical Use of an IDM2909A as a Microprogram Sequencer in a Computer Control Unit



# 2900 Family/ Bipolar Microprocessor PRELIMINARY

# **IDM2910A Microprogram Controller**

## **General Description**

The IDM2910A Microprogram Controller is a 12-bit wide address controller packaged in a standard 40-pin dual-in-line package. The IDM2910A features TRI-STATE® outputs and is fabricated using SCL (Schottky ECL) technology. The IDM2910A is a microprogram memory address controller that controls the execution sequence of microinstructions. In addition to being able to sequentially access memory, the IDM2910A is also able to conditionally branch to any microinstruction within the 4096 microinstruction range. A five-level last-in, first-out (LIFO) stack provides microsubroutine return linkage. An internal loop counter is included to provide the repeating instructions or perform up to 4096 loop iterations.

As each microinstruction is executed, the IDM2910A selects a 12-bit address from one of four sources:

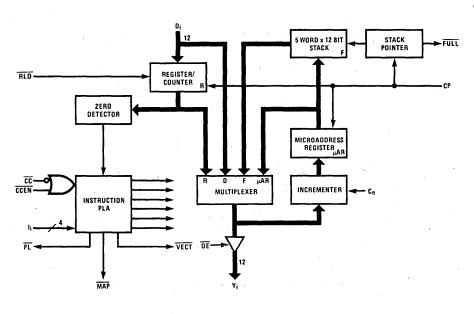
- The Microprogram Address Register which usually contains the increment address of the previous microinstruction.
- 2. The external Direct Input lines,
- The Register/Counter which contains an address or data loaded during a previous microinstruction.
- 4. The LIFO Stack.

### **Features and Benefits**

- Twelve-bit wide address controls up to 4096 words of microcode with one device
- Internal register/counter a 12-bit down-counter that may be used to count loop iterations
- Four address sources the next microprogram address selected from the microprogram address/ register data input lines, LIFO stack, or register counter
- Sixteen powerful microinstructions executes 16 sequence control instructions
- Output enables for three branch address sources

   replaces either external decoder or additional
   bit of microcode
- Positive-edge triggering for all internal registers
- Fast condition-code control typically a 19ns delay from a condition-code input to an address output
- SCL technology provides ECL speeds while maintaining low-power Schottky power consumption
- 100% reliability testing in compliance with MIL-STD-883.

# **IDM2910A Block Diagram**



### **Absolute Maximum Ratings**

Storage Temperature
Temperature (Ambient) Under Bias
Supply Voltage to Ground Potential
DC Voltage Applied to Outputs
for High Output State
DC Input Voltage
DC Output Current, into Outputs
DC Input Current
DC Input Current

-65 °C to +150 °C
-0.5V to +6.3V
-0.5V to +6.3V
-0.5V to +V<sub>CC</sub> max
-0.5V to +5.5V
-0.5V to +5.5V
-0.5V to +5.5V
-0.5V to +5.5V
-0.5V to +5.5V
-0.5V to +5.5V
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-0.5V to +5.5V
-0.5V to +5.5V
-0.5V to +5.5V
-0.5V to +5.5V
-0.5V to +5.5V
-0.5V to +5.5V

# **Operating Range**

Part Number

Ambient Temperature

Vcc

IDM2910A JC, NC

0°C to +70°C 4.75V to 5.25V

IDM2910A JM, JM/883 -

-55°C to +125°C 4.50V to 5.50V

# Standard Screening (Conforms to MIL-STD-883 for Class C parts)

	MILSTD-883		Level		
Step	Method	Conditions	DC, NC	DM	
Pre-Seal Visual Inspection	2010	В	100%	100%	
Stabilization Bake	1008	C: 24-hour 150 °C	100%	100%	
Temperature Cycle	1010	C: -65°C to +150°C 10 cycles	100%	100%	
Centrifuge	2001	B: 10,000 G	100%*	100%	
Fine Leak	1014	A: 5×10 <sup>-8</sup> atm-cc/cm <sup>3</sup>	100%*	100%	
Gross Leak	1014	C2: Fluorocarbon	100%*	100%	
Electrical Test Subgroups 1, 7, and 9	5004	See below for definitions of subgroups	100%	100%	
Insert Additional Screening here f	or Class B parts				
Group A Sample Tests Subgroup 1 Subgroup 2 Subgroup 3 Subgroup 7 Subgroup 8 Subgroup 9	5005	See below for definitions of subgroups	LTPD = 5 LTPD = 7 LTPD = 7 LTPD = 7 LTPD = 7 LTPD = 7	LTPD = 5 LTPD = 7 LTPD = 7 LTPD = 5 LTPD = 7 LTPD = 5	

<sup>\*</sup>Not applicable to IDM2910ANC.

# Additional Screening for Class B Parts

Step	MIL-STD-883 Method	Conditions	Level DM/883
Burn-In	1015	D: 125 °C, 160 hours min	100%
Electrical Test	5004		
Subgroup 1			100%
Subgroup 2			100%
Subgroup 3			100%
Subgroup 7	'		100%
Subgroup 9		•	100%

### **Group A Subgroups**

(as defined in MILSTD-883, method 5005)

Subgroup	Parameter	Temperature
1	DC	25°C
2	DC	Maximum rated temperature
3	DC	Minimum rated temperature
7	Function	25°C
8	Function	Maximum and minimum rated temperature
9	Switching	25°C
10	Switching	Maximum rated temperature
11	Switching	Minimum rated temperature

### **Electrical Characteristics**

The following conditions apply unless otherwise specified:

Comm'l  $T_A = 0$  °C to +70 °C  $V_{CC} = 5.0 V \pm 5\%$  min = 4.75 V max = 5.25 V Mil  $T_C = -55$  °C to +125 °C  $V_{CC} = 5.0 V \pm 10\%$  min = 4.50 V max = 5.50 V

# **DC Characteristics over Operating Range**

Symbol	Description	Test Conditions (Note 1)	Min	Typ (Note 2)	Max	Units
V <sub>он</sub>	Output HIGH Voltage	$V_{CC} = min, I_{OH} = -5mA,$ $V_{IN} = V_{IH} \text{ or } V_{IL}$	2.4			٧
V <sub>OL</sub>	Output LOW Voltage	$V_{CC}$ = min, $V_{IN}$ = $V_{IH}$ or $V_{IL}$ , $Y_{0-11}$ $I_{OL}$ = 12 mA (Comm'l) $Y_{0-11}$ $I_{OL}$ = 12 mA (Mil) PL, VECT, MAP, FULL $I_{OL}$ = 8 mA		,	0.5	<b>'V</b>
V <sub>IH</sub>	Input HIGH Level (Note 4)	guaranteed input logical HIGH voltage for all inputs	2.0			٧
V <sub>IL</sub>	Input LOW Level (Note 4)	guaranteed input logical LOW voltage for all inputs			0.8	٧
$V_{l}$	Input Clamp Voltage	$V_{CC} = min, I_{IN} = -18 mA$			-1.5	٧
1 <sub>IL</sub>	Input LOW Current	$V_{CC} = max$ , $V_{IN} = 0.5V$			-0.36	mA
l <sub>iH</sub>	Input HIGH Current	$V_{CC} = max, V_{IN} = 2.7V$			30	μА
l <sub>l</sub>	Input HIGH Current	$V_{CC} = max$ , $V_{IN} = 5.5 V$			1.0	mA
I <sub>sc</sub>	Output Short Circuit Current (Note 3)	V <sub>CC</sub> = max	- 20		-85	mA
lozL	Output OFF Current	$V_{CC} = max, \overline{OE} = 2.4V,$ $V_{OUT} = 0.5V$			-50	μΑ
l <sub>OZH</sub>	Output OFF Current	V <sub>CC</sub> = max, OE = 2.4V, V <sub>OUT</sub> = 2.4V			50	μА
1 <sub>CC</sub>	Power Supply Current	$V_{CC} = max T_A = 25 °C$		160	245	mA
	IDM2910A DC, NC	T <sub>A</sub> =0°C to +70°C			260	mA
		T <sub>A</sub> = +70°C			220	mA
	IDM2910A DM, DM/883	T <sub>C</sub> = -55°C to +125°C	<u> </u>		275	mA
		T <sub>C</sub> = +125°C			185	mA

#### Notes:

- For conditions shown as min or max, use the appropriate value specified under Electrical Characteristics for the applicable device type.
- 2. Typical limits are at  $V_{CC} = 5.0 \text{ V}$ , 25 °C ambient and maximum loading.
- 3. Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.
- 4. These input levels provide no guaranteed noise immunity and should be tested only in a static- and noise-free environment.

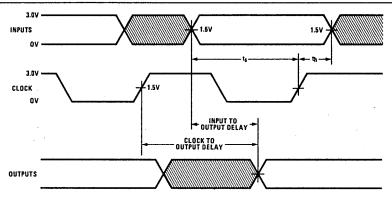


Figure 1. Switching Waveforms

Setup  $(t_S)$  and hold  $(t_h)$  times for varied inputs are listed in Table A. Combinational input to output delays are listed in Table B. Clock requirements are listed in Table C. See Figure 3, Switching Waveform Timing, for a typical cycle.

# **Switching Characteristics**

(Refer to Figure 1.)

IDM2910A switching characteristics for the typical, commercial and military operating ranges available are given in Tables A, B, and C on this page and the following page.

Table A contains setup and hold times with respect to the clock low-to-high transition. Table B contains combinational delays from input to output. Table C contains the clock requirements.

All measurements are made at 1.5V with input levels at 0V or 3V. All times are in nanoseconds.

# **Typical Room Temperature Characteristics**

 $(T_A = 25 \,^{\circ}\text{C}, V_{CC} = 5.0 \,\text{V}, C_L = 50 \,\text{pF})$ 

#### A. Setup and Hold Times

Input	t <sub>s</sub>	t <sub>h</sub>
D <sub>i</sub> → R	11	6
D <sub>i</sub> → AR	15	6
10-13	35	6
CC	22	6
CCEN	21	6
C <sub>n</sub>	19	6
RLD	21	6

#### **B.** Combinational Delays

Input	Y	PL, VECT, MAP	FULL
D <sub>0</sub> -D <sub>11</sub>	14	_	_
10-13	24	20	
CC	21	-	-
CCEN	21	_	_
CP I = 8, 9, 15	28	-	-
CP (Note) I = 8, 9, 15	28	-	_
CP All Other I	24		28
ŌĒ	15/15	_	-

Note: If the instruction prior to the clock was 4 or 12 or  $\overline{\text{RLD}}$  was low, delays are as listed.

#### C. Clock Requirements

	Minimum Clock LOW Time	25	ns
Г	Minimum Clock HIGH Time	25	ns
Г	Mínimum Clock Period, I = 8, 9, 15	50	ns
Γ	Minimum Clock Period, I = 14	50	ns

Clock periods for other instructions are determined by external conditions.

# **Guaranteed Characteristics over Commercial Operating Range**

IDM2910A DC, NC

 $(T_A = 0 \,^{\circ}\text{C to } + 70 \,^{\circ}\text{C}, V_{CC} = 4.75 \,\text{V to } 5.25 \,\text{V}, C_L = 50 \,\text{pF})$ 

#### A. Setup and Hold Times

· Input	t,	th
D <sub>i</sub> → R	14	0
D <sub>i</sub> → AR	25	0
I <sub>0</sub> -I <sub>3</sub>	35	0
CC	35	0
CCEN	35	0
C <sub>n</sub>	30	0
RLD	25	0

#### **B.** Combinational Delays

Input	° <b>Y</b>	PL, VECT, MAP	FULL
D <sub>0</sub> -D <sub>11</sub>	20	_	_
10-13	35	30	_
CC	35	<b>—</b>	_
CCEN	35	_	_
CP I = 8, 9, 15	45		-
CP (Note) I = 8, 9, 15	45	-	_
CP All Other I	35	_	.30
ŌĒ	25/25		٠ ـــ

Note: If the instruction prior to the clock was 4 or 12 or  $\overline{\text{RLD}}$  was low, delays are as listed.

#### C. Clock Requirements

Minimum Clock LOW Time	30	ns
Minimum Clock HIGH Time	30	ns
Minimum Clock Period, I = 8, 9, 15	60	ns ,
Minimum Clock Period, I = 14	- 60	ns

Clock periods for other instructions are determined by external

# **Guaranteed Characteristics over Military Operating Range**

IDM2910A DM, DM/883

 $(T_A = -55 \,^{\circ}\text{C to } + 125 \,^{\circ}\text{C}, \, V_{CC} = 4.5 \,^{\circ}\text{V to } 5.5 \,^{\circ}\text{V}, \, C_L = 50 \,^{\circ}\text{pF})$ 

#### A. Setup and Hold Times

Input	t,	t <sub>h</sub>
$D_i \rightarrow R$	17	0
D <sub>i</sub> → AR	30	0
I <sub>0</sub> -I <sub>3</sub>	40	0
CC	40	0
CCEN	40	0
Cn	35	0
RLD	30	0

#### **B.** Combinational Delays

Input	Y	PL, VECT, MAP	FULL
D <sub>0</sub> - D <sub>11</sub>	25		_
10-13	40	35	. –
CC	40	_	_
CCEN	40	-	_
CP 1 = 8, 9, 15	55		-
CP (Note) I = 8, 9, 15	55	-	_
CP All Other I	40	_	35
ŌĒ	25/25	-	_

Note: If the instruction prior to the clock was 4 or 12 or  $\overline{\text{RLD}}$  was low, delays are as listed.

#### C. Clock Requirements

Minimum Clock LOW Time	35	ns
Minimum Clock HIGH Time	35	ns
Minimum Clock Period, I = 8, 9, 15	70	ns
Minimum Clock Period, I = 14	70	ns

Clock periods for other instructions are determined by external

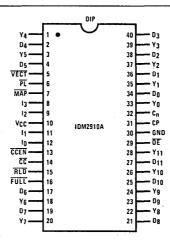


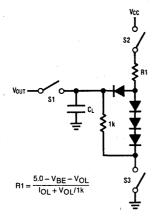
Figure 2. Pin Connection Diagram

Table 1. IDM2910A Pinout Descriptions

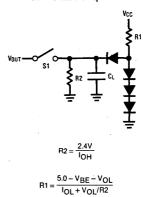
Abbreviation	Name	Function
D <sub>i</sub> , i = 0 to 11	Direct Inputs	12 direct input lines carrying data into the register/counter or a jump address to be used by the multiplexer. D <sub>0</sub> is LSB.
$l_i$ , $i = 0$ to 3	Instruction Lines	Four instruction lines. Select one-of-sixteen control instructions for the IDM2910A.
CC	Condition Code	The outcome of a test is input through this line into the IDM2910A so that it may be used in conditional control instructions. A low on CC is interpreted as PASS test.
CCEN	Condition Code Enable	Conditional control based on the $\overline{CC}$ input is enabled as long as $\overline{CCEN}$ is low. A high on $\overline{CCEN}$ overrides the $\overline{CC}$ input and the IDM2910A will operate as if $\overline{CC}$ were low.
C <sub>n</sub>	Carry In	The carry input to the address register incrementer.
RLD	Register Load	When LOW, will force a load of the register/counter on the next rising edge of the clock. Loading will be performed regardless of instruction or condition.
ŌĒ	Output Enable	The TRI-STATE® control of Y <sub>i</sub> outputs.
CP	Clock Pulse	All internal state changes are triggered by the rising edge of the clock.
V <sub>CC</sub>	+5 Volts	
GND	Ground	
$Y_i$ , $i = 0$ to 11	Address Outputs	12 address output lines to be used by the microprogram memory in accessing the next microword. Y <sub>0</sub> is LSB.
FULL	Full Stack	This output will go low one microcycle after the stack becomes full.
PL	Pipeline Address Enable	May be used to enable the first of three sources (usually pipeline register) onto the branch address bus connected to the D <sub>i</sub> inputs.
MAP	Map Address Enable	May be used to enable the second of three sources (mapping ROM, PROM or RAM) onto the branch address bus connected to the $\mathrm{D}_{\mathrm{l}}$ inputs.
VECT	Vector Address Enable	May be used to enable the third of three sources (usually interrupt starting address) onto the branch address bus connected to the D <sub>i</sub> inputs.

# **Test Output Load Configurations for IDM2910A**

#### A. Three-State Outputs



#### **B. Normal Outputs**



Note 1:  $C_L = 50$  pF includes scope probe, wiring and stray capacitances without device in test fixture.

Note 2: S1, S2, S3 are closed during function tests and all AC tests except output enable tests.

Note 3: S1 and S3 are closed while S2 is open for tpZH test.

S1 and S2 are closed while S3 is open for tpzL test.

Note 4:  $C_L = 5.0 \text{ pF}$  for output disable tests.

# Test Output Loads for IDM2901A

Pin # (DIP)	Pin Label	Test Circuit	R1	R2
_	Y <sub>0-11</sub>	Α	300	1k
5	VECT	B ·	470	1.5k
6	PL	В	47.0	1.5k
7	MAP	В	470	1.5k
16	FULL	В	470	1.5k

### The IDM2910A Microinstruction Set

The IDM2910A executes sixteen control instructions. These instructions perform specific functions in addition to the selection of the next microcode word to be executed.

Four of the control instructions are unconditional — the function performed is specified only by the instruction itself

Ten of the control instructions are conditional branches — based upon the state of an external data-dependent test. Since test results may be forced by suitable circuitry, it follows that the ten control instructions may also be used as unconditionals.

Three of the instructions allow conditional sequencing based upon the contents of the internal register/counter.

The IDM2910A instruction control set is shown in Table 2. One of the conditional branch control instructions is dependent on the external data test and the contents of the internal register/counter.

For the following discussion it is assumed that  $\mathbf{C}_{n}$  is tied high.

For the ten conditional control instructions, the results of data dependent tests are applied to the condition code input,  $\overline{CC}$ . If the input to  $\overline{CC}$  is low, the test is considered passed and the action specified under "PASS" (Table 2) will be taken. If the input to  $\overline{CC}$  is high, the test is considered failed and the alternate action is taken. In many cases, the alternate action is the selection of the sequentially incremented address. By setting  $\overline{CCEN}$  high for any specific microinstruction,  $\overline{CC}$  testing will be disabled and a "PASS" will be forced. Other suggestions for using  $\overline{CCEN}$  to save one bit of microcode are:

- If there is no data-dependent microcode, CCEN can be tied high.
- If data-dependent control instructions are never forced unconditionally, CCEN can be tied low.
- If CCEN is tied to the source of the IDM2910A instruction bit I<sub>0</sub>, control instructions 4, 6, and 10 are left as data-dependent, and the others are made unconditional.

Several of the IDM2910A inputs may be used to modify instruction execution. For 10 of the 16 instructions, the combination of  $\overline{CC}$  high and  $\overline{CCEN}$  low is used as a test. When  $\overline{RLD}$  is low, the direct inputs are loaded into the register/counter overriding any HOLD or DECREMENT (DEC) operation specified in the microinstruction. The  $\overline{OE}$  input, normally low, may be driven high to place the Y outputs in the TRI-STATE® condition.

The LIFO stack contains a 5-word, 12-bit file memory and a stack pointer which addresses the value presently at the top of the stack. Actual control over the stack pointer is possible when using microinstruction 0 (JUMP ZERO or RESET). This microinstruction clears the stack by resetting the stack pointer to zero. The contents at the top of the stack will remain undefined following execution of microinstruction 0, or whenever the stack becomes empty. Any pops performed while the stack is empty will place an undefined address at the F inputs to the multiplexer and the stack pointer will remain at zero.

If five more pushes than pops have occurred since the stack was last empty, the stack will become full. Once the stack is full, the FULL output will go low. FULL will go low on the first microcycle following the fifth push. If any additional push operations are performed on a full stack, the stack becomes overwritten and any previous information is lost.

Table 2. IDM2910A Microinstruction Set

Hex I <sub>3</sub> -I <sub>0</sub>	Mnemonic Name	Reg/Cntr Contents	FAIL CCEN = LOW and CC = HIGH		CCEN	ASS = HIGH = LOW	Reg/ Cntr	Enable	
				Y	Stack	Y	Stack		
0	JZ ·	JUMP ZERO	×	0	CLEAR	0	CLEAR	HOLD	PL
1	CJS	COND JSB PL	Х	PC	HOLD	D	PUSH	HOLD	PL
2	JMAP	JUMP MAP	×	D	HOLD	D	HOLD	HOLD	MAP
3	CJP	COND JUMP PL	Х	PC	HOLD	D	HOLD	HOLD	PL
4	PUSH	PUSH COND LD CNTR	×	PC	PUSH	PC	PUSH	Note 1	PL
5	JSRP	COND JSB R/PL	Х	R	PUSH	D	PUSH	HOLD	PL
6	CJV	COND JUMP VECTOR	Х	PC	HOLD	D	HOLD	HOLD	VECT
. 7	JRP	COND JUMP R/PL	×	R	HOLD	.D	HOLD	HOLD	PL
8.	RFCT	REPEAT LOOP, CNTR # 0	≠ 0	F	HOLD	F	HOĽĎ	DEC	PL
			= 0	PC	POP	PC	POP	HOLD	· PL
9	RPCT	CT REPEAT PL, CNTR ≠ 0	≠ 0	D	HOLD	D	HOLD	DEC	PL
3	nro1	NEFERI PL, CIVIN # 0	= 0	PC	HOLD	PC	HOLD	HOLD	PL
A	CRTN	COND RTN	Х	PC	HOLD	F	POP	HOLD	PL
В	CJPP	COND JUMP PL & POP	×	PC	HOLD	D	POP	HOLD	PL
С	LDCT	LD CNTR & CONTINUE	Х	PC	HOLD	PC	HOLD	LOAD	PL
D	LOOP	TEST END LOOP	Х	F	HOLD	PC	POP	HOLD	PL
E	CONT	CONTINUE	Х	PC	HOLD	PC	HOLD	HOLD	PL
F	TWB	THREE-WAY BRANCH	<b>≠</b> 0	F	HOLD	PC	POP	DEC	PL
	1440	THREE-WAT BRANCH	= 0	D	POP	PC	POP	HOLD	PL

Note 1: If  $\overline{CCEN} = LOW$  and  $\overline{CC} = HIGH$ , hold; else load. X = Don't Care.

### **IDM2910A Architecture**

The IDM2910A Bipolar Microprogram Controller is intended for use in very high-speed microprocessor applications. Up to 4096 microwords may be addressed using the IDM2910A.

A multiplexer within the IDM2910A selects one of four inputs as the source of the next microinstruction address. The four sources are:

- 1. the microprogram address register (µAR)
- 2. the register/counter
- 3. the direct input lines
- 4. the LIFO stack
- The Microprogram Address Register contains a twelve-bit incrementer followed by a twelve-bit register. Two uses for the microprogram address register are:
  - a. When carry-in (C<sub>n</sub>) is high, the current microprogram address plus one (Y<sub>i</sub> + 1) is loaded into the address register on the next positive clock transition. Therefore, microprogram words are accessed sequentially.
  - b. When carry-in (C<sub>n</sub>) is low, the current microprogram address is passed through the incrementer and loaded into the address register on the next position clock transition. Thus, the same microinstruction may be repeated as often as is required.
- 2. The register/counter contains twelve D-type edge-triggered flip-flops with a common clock enable. When the register load control (RLD) is low, addresses from the direct input bus are loaded into the register on the next positive-going clock. Some sequence control instructions include a load operation. For most microcomputer systems, these instructions will be sufficient, thereby simplifying the microcode.
- The Direct Input lines are a direct input source which may be used for microprogram branching.
- The LIFO stack is a 5-word by 12-bit stack used to provide return address linkage when executing microsubroutines or loops. The stack incorporates a

5×12 file (RAM) and a stack pointer that always points to the last entry into the file. Stack reference operations (microprogram looping) may be executed without popping the stack.

The stack pointer is an up/down counter that is incremented whenever a push operation is performed (microinstructions 1, 4, and 5). Once the pointer is incremented, the return address is written into the location indicated by the stack pointer on the positive-going clock following the push.

The stack pointer is decremented whenever the pop operation is performed (microinstructions 8, 10, 11, 13, and 15). The stack pointer is decremented on the positive-going clock following a pop, effectively removing the return address from the top of the stack.

Stack pointer linkage is such that any combination of pushes, pops, or stack references may be performed. For control instruction 0 (JUMP ZERO or RESET), the stack pointer is reset. For each push operation, the microsubroutine nesting depth is increased by one; for each pop operation, the depth decreases by one. The maximum nesting depth is five. Once the stack becomes full, FULL goes low and the stack pointer can no longer be incremented. Further pushes will write over the preceding address at the top of the stack. A pop from an empty stack (stack pointer at zero) will place a meaningless address on the Y outputs, and the stack pointer will remain at zero. A stack pointer at zero remains unchanged by any number of additional pops.

The register/counter operates as a twelve-bit down-counter during microinstructions 8, 9, and 15, with register contents zero as a branch condition. This branch condition provides efficient repetition of microinstructions. The internal arrangement of the register/counter is such that if a number N is loaded into it and the register is used as a loop termination counter, the sequence will be executed N+1 times. A three-way branch condition is available (control instruction 15) under control of both the register/counter and the condition code input (CC).

The Y output lines are TRI-STATE, allowing the Y outputs to be disabled. When disabled (via  $\overline{OE}$ ), the address lines can be externally driven, allowing automatic checkout of the microcomputer system.

Architectures Using the IDM2910A

Shading illustrates paths which can limit speed.

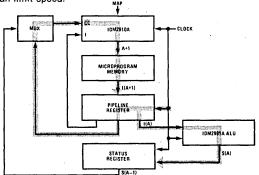


Figure 3a. Single-Level Pipeline Based Architecture

A one-level pipeline provides for better speed than most other architectures. The IDM2910A array and the microprogram memory are in parallel speed paths, rather than in series. This architecture is recommended for IDM2910A designs.

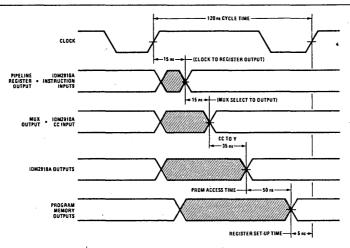


Figure 3b. Typical Timing Waveform for Single-Level Pipeline Based Architecture

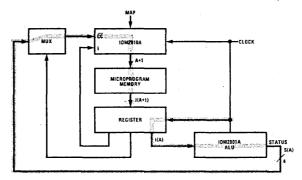


Figure 4. Instruction Based Architecture

The microinstruction being executed is in the register at the microprogram memory output. The IDM2910A and the microprogram memory are in series. Any conditional branches are executed on the same cycle as the ALU operation generating the condition.

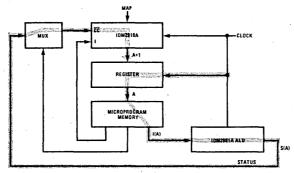


Figure 5. Address Based Architecture

The address of the microinstruction being executed is in the register at the IDM2910A output. The IDM2910A and the microprogram memory are in the critical path. This architecture operates at approximately the same speed as the instruction based architecture, but requires fewer register bits because only the address (typically 10 to 12 bits) is stored instead of the instruction (typically 40 to 60 bits).

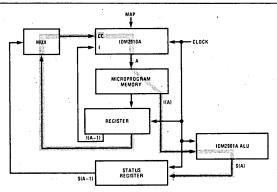


Figure 6. Data Based Architecture

The status register provides for conditional branch control based upon the results of the previous ALU cycle. The IDM2910A and the microprogram memory are in the critical path.

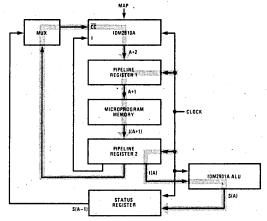


Figure 7. Two-Level Pipeline Architecture

The two-level pipeline provides the maximum possible speed, but is more difficult to program because the selection of a microinstruction occurs two microinstructions ahead of its execution.

# **IDM2910A Operation**

The results of each instruction in determining the Y outputs, and the controlling of the three enable signals (PL, MAP, VECT) are given in Table 2. Also shown is the effect of the microinstructions on the register/counter and the stack after the next positive-going clock. The multiplexer determines which of the internal sources drive the Y output lines. Depending upon the condition of Cn, the address loaded into the microprogram address register will be identical to the Y outputs, or will be one greater. For each microinstruction, only one of the three enable outputs (PL, MAP, or VECT) is low. These three enable signals may be used to control the TRI-STATE® outputs of three external sources of microprogram address to allow them to drive the direct input bus (D<sub>i</sub>) without additional logic. The external sources are:

- A source of microprogram jumps (usually part of a pipeline register).
- 2. A PROM which maps machine language to a microinstruction starting location (entry point).

3. An optional third source of microinstructions (often a vector from a DMA or interrupt source).

The function performed by three of the control instructions depends upon the contents of the register/counter. The counter is decremented if it contains a non-zero value. If the value in the counter is zero, it is held and a different microprogram next-address is selected. These types of instructions are useful for executing a microinstruction loop a known number of times. The three-way branch control instruction (number 15) is affected by both the external condition code  $\overline{CC}$  and the contents of the register/counter.

The following paragraphs describe each of the IDM2910A control instructions. Included with each of the descriptions is an execution flowchart showing typical microprogram flow.

Each of the examples is intended to show a typical microprogram flow as various microprogram control instructions are executed. The typical circuit of Figure 3 is assumed.

The microprogram addresses in the illustrations were chosen arbitrarily and have no significance other than

to illustrate microprogram flow, the only exception being control instruction 0, JZ (JUMP ZERO or RESET), which always selects the next address to be zero.

Execution flowcharts should be interpreted as follows:

Each dot relates to one microcycle. While this microcycle is going on the IDM2910A control instruction will be supplied by the microprogram memory word presently in the pipeline register.

A dot surrounded by a circle refers to the control instruction under discussion. Dashed lines refer to conditional actions. Solid lines refer to unconditional actions or to the outcome of =Test Falled= in conditional control instructions.

Dashed arrows refer to conditional branches (address changes other than sequential flow), which will be selected if the test is passed (CC = LOW). Solid arrows refer to unconditional branches or to the outcome of =Test Failed = in conditional control instructions.

Parentheses ( ) should be read "contents of," e.g.,  $(D_i) = \text{contents of } D_i$ .

#### Control Instruction 0

JZ (Jump Zero or Reset) — This control instruction clears the stack pointer and specifies unconditionally that the next address is zero. This control instruction is useful for power-up sequences if the initialization routines start at microprogram memory location zero.

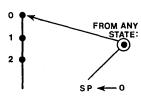


Figure 8. JUMP ZERO (JZ)

#### Control Instruction 1

CJS (Conditional Jump-to-Subroutine) — This control instruction executes a conditional jump to a subroutine located at the address found in the pipeline register. Referring to Figure 9, the unconditional microprogram flow is from address 50 through address 52. When the contents of address 52 are in the pipeline register, the next address control instruction is CJS. If the conditional test is passed, address 53 will be pushed onto the stack and the next instruction executed will be at address 90. The address pushed onto the stack provides a return link once the microsubroutine starting at address 90 is completed. For example, a Return-from Subroutine (CRTN, control instruction 10) was executed at address 93. If the conditional test fails, the Jump-to-Subroutine will not be executed and the contents at address 53 will be executed. In this manner, the CJS control instruction at address 52 will cause the microprogram word at either address 90 or address 53 to be executed.

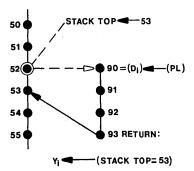


Figure 9. COND JSB PL (CJS)

#### **Control Instruction 2**

JMAP (Jump-Map) — This is an unconditional jump control instruction. When JMAP is executed, the MAP output is enabled and the next microinstruction address is taken from the mapping PROMs. The JMAP control instruction is normally used towards the end of an instruction-fetch sequence for the microcomputer. At that time the next instruction to be executed should be valid, allowing it to be mapped into the corresponding entry point.

For the example shown, the microinstructions at addresses 50 through 53 would be the fetch sequence, with 53 being the sequence completion. The JMAP control instruction would be contained in the pipeline register with the mapping PROM generating an address 90. Address 90 would be selected by the IDM2910A as the next address to be presented to microprogram memory.

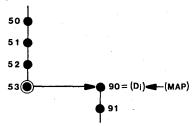
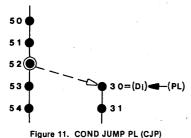


Figure 10. JUMP MAP (JMAP)

#### **Control Instruction 3**

CJP (Conditional Jump Pipeline) — This control instruction derives its branch address from the pipeline register branch address field (BR $_0$  through BR $_{11}$ ). See the typical microcomputer system, Figure 11. A technique is thus provided for branching to various microprogram sequences depending upon the state of the condition code inputs (CCEN and CC). Statemachines may be designed to execute tests on various inputs and to wait for the condition to go true. When the condition does go true, the system branches and performs a specific function. When the branch occurs, the particular input is usually reset until some point in the future. With CCEN high, this control instruction is the one to use for unconditional jumps.

The example illustrates a conditional jump via the address value defined by the microprogram word located at address 52. When the contents of address 52 are in the pipeline register, the next address passed through the IDM2910A will be either address 53 or address 30, depending upon the state of the condition code input. If the test passes, the address value in the pipeline register (address 30) will be selected by the IDM2910A. If the test fails, the next sequential address (address 53) contained in the micro address register (µAR) will be selected.



#### Control Instruction 4

#### PUSH (Unconditional Push/Conditional Load Counter)

- This control instruction is primarily used to set up microprogram loops in the microprogram. As shown in Figure 12, when microcode word 52 is in the pipeline register, a push operation is performed on the stack and depending upon the condition code inputs, the register/ counter is loaded. A push operation causes the next sequential address (address 53) to be pushed onto the stack. If the condition code test fails, the register/ counter is not loaded. If the condition code test passes, the register/counter is loaded with the address value in the pipeline register branch address field. In this manner, a single control instruction can set up a microprogram loop to be executed a specific number of times. While setup is being performed the IDM2910A will unconditionally select the next sequential address contained in the micro address register to be presented to the memory. Control instruction 8 (RFCT) describes the use of the pushed value and the register/counter contents for looping.

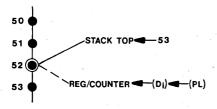


Figure 12. PUSH, COND LD CNTR (PUSH)

#### Control Instruction 5

JSRP (Conditional Jump-to-Subroutine) — This control instruction is a conditional jump to a subroutine via either the contents of the register/counter or the pipeline register.

As shown in Figure 13, a push operation is always performed and one of two microsubroutines is executed. For this example, either the microsubroutine at address 80 or the microsubroutine at location 90 will be executed. A Return-from-Subroutine (CRTN, control instruction 10) at the end of the microsubroutine will pop the return address (location 55) from the stack. In order for this microinstruction control sequence to operate correctly, the next address fields of both microinstructions 53 and 54 must contain the proper address value. As an example, the next address field of microinstruction 53 must contain address value 90 and microinstruction 54 must contain address value 80. Microinstruction 53 must be loaded into the register/counter while microinstruction 54 is in the pipeline register. If a JSRP is executed at address 54 and the condition code test fails, the contents of the register/counter will be passed through the IDM2910A as the address (address 90) of the next microinstruction. If the condition code test passes, the address value in the pipeline register will be passed through the IDM2910A as the address (address 80) of the next microinstruction. Therefore, this control instruction (JSRP) has the capability of selecting one of two microsubroutines, based upon the results of a condition code test.

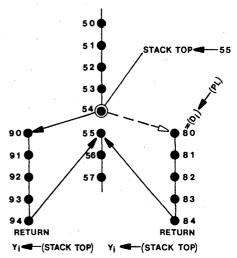


Figure 13. COND JSB R/PL (JSRP)

#### **Control Instruction 6**

CJV (Conditional Jump Vector) — This is a conditional jump control instruction. When CJV is executed, the VECT output is enabled and the next microinstruction address is taken from an address generator. The VECT line must control the TRI-STATE® enable line of a register, a buffer, or a PROM, containing the next microprogram address. This instruction provides one technique for performing interrupt type branching at the microprogram level. Since CJV is a conditional control instruction, passing the condition code inputs will allow the vector source address to pass through the IDM2910A. If the condition code test fails the next sequential address will be taken from the address register.

As shown in Figure 14, if CJV is at location 52, and the condition code test passes, microprogram execution will jump to vector address 20 and continue. If the condition code test fails, microprogram execution will continue at address 53.

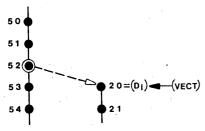


Figure 14. COND JUMP VECTOR (CJV)

#### **Control Instruction 7**

JRP (Conditional Jump) — This control instruction is a conditional jump to another routine via the contents of either the register/counter or the pipeline register. JRP is similar to JSRP (control instruction 5), except that no push onto the stack is performed for JRP.

The example shown in Figure 15 shows JRP as a branch to one of two addresses, depending upon the results of the condition code test. Assume the pipeline register contains an address value of 70 when the contents of address 52 are being executed. As the contents of address 53 are clocked into the pipeline register, the address value of 70 is loaded into the register/counter. If the address value of 80 is available when the contents of address 53 are in the pipeline register, either address 70 or address 80 will be passed through the IDM2910A, depending upon the results of the condition code test.

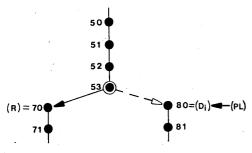


Figure 15. COND JUMP R/PL (JRP)

#### Control Instruction 8

RFCT (Repeat Loop, Counter Not Equal to Zero) — This control instruction uses the decrementing ability of the register/counter to loop on one or more microinstructions. A preceding instruction, such as PUSH, must have loaded a count value into the register/counter while pushing the next address onto the stack. RFCT tests the register/counter for a non-zero value. If the counter is non-zero, the register/counter is decremented by one and the address of the next instruction is taken from the top of the stack. This sequence will repeat until the register/counter equals zero (the exit condition has

been met), causing the next sequential address to be selected  $(Y_i = \mu AR)$ . The stack is popped since looping back is not required anymore.

As shown in Figure 16, a PUSH control instruction would most likely be at address 50. The PUSH will cause address 51 to be pushed onto the stack and will load the register/counter with the count value contained in the pipeline register branch address field.

For this example, the loop test is made at the end of the loop routine (address 54), so the value loaded into the register/counter must be one less than the desired number of passes through the loop. Using the method in the example, a loop may be executed from 1 to 4096 times

The ability to perform single-microinstruction loops is an efficient way to execute the same microinstruction a specified number of times. Examples are fixed rotates, byte swap, fixed point multiply, and fixed point divide.

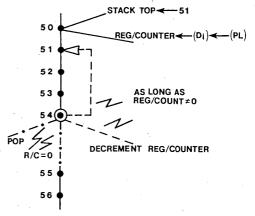


Figure 16. REPEAT LOOP, CNTR ≠ 0 (RFCT)

#### Control Instruction 9

RPCT (Repeat Pipeline Register, Counter Not Equal to **Zero)** — This control instruction uses the decrementing ability of the register/counter to loop on one or more RPCT is similar to control microinstructions. instruction RFCT (control instruction 8) except the branch address is taken from the pipeline register whereas RFCT takes it from the file. As long as the register/counter is not zero, RPCT will decrement the value in the register/counter and branch to the address taken from the pipeline register through the D<sub>i</sub> inputs. Once the register/counter equals zero, the next address will be selected  $(Y_i = \mu AR)$ . For some cases, this control instruction can be considered to be a one-word extension of the stack. By using RPCT, a microprogram loop using the register/counter can be executed, even though the stack may be completely full. A preceding control instruction must have loaded a count value into the register/counter. RPCT does not perform a pop operation because the stack is not being used.

As shown in Figure 17, microinstruction 51 could be Load Counter and Continue (LDCT, control instruction 12). RPCT is the control instruction at 52 and is shown as a single microinstruction loop. The address in the

pipeline register would be 52. Although a single microinstruction loop is shown, by changing the address in the pipeline register, multi-instruction loops may be performed for a fixed number of times.

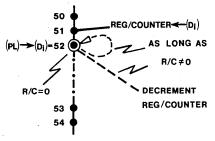


Figure 17. REPEAT PL, CNTR ≠ 0 (RPCT)

#### Control Instruction 10

CRTN (Conditional Return-from-Subroutine) — This control instruction is used to return from a microsubroutine to the control instruction immediately following the microsubroutine call. CRTN is a conditional return, with the return occurring only if the condition code test passes. If the condition code test fails, the next sequential microinstruction will be executed.

As shown in Figure 18, the use of CRTN is illustrated for both the conditional and the unconditional modes. A Jump-to-Subroutine control instruction is executed at address 52, pushing return address 53 onto the stack and transferring control to address 90. A CRTN is executed at address 93. If the condition code test passes, the microprogram returns to address 53 and the stack is popped. If the condition code test falls, execution continues through to address 97, where the microsubroutine is considered complete. CRTN must now be executed unconditionally. The microinstruction at address 97 is programmed to force CCEN high, disabling the condition code test, with the forced pass causing an unconditional return.

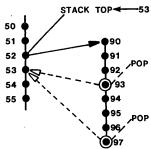


Figure 18. COND RETURN (CRTN)

#### Control Instruction 11

CJPP (Conditional Jump Pipeline Register Address and Pop Stack — This control instruction provides another method of loop termination and stack maintenance. CJPP is a conditional jump, with the jump occurring only if the condition code test passes. A stack pop will also occur since this jump terminates the loop (whose branch address is located in the stack top).

As shown in Figure 19, a return address is pushed onto the stack and is followed by a short loop. The micro-instructions at addresses 52, 53, and 54 are all GJPP control instructions. At address 52, if the condition code test passes, a branch to address 70 and a stack pop will occur. If the condition code test fails, the next sequential address (address 53) will be selected. The same conditions exist for the microinstructions at addresses 53 and 54, with 53 pointing to either address 90 or address 54, and 54 pointing to either address 80 or address 55. Used in this sort of loop, the CJPP control instruction is very useful when several inputs require testing before proceeding to other instructions. This provides the powerful jump-table programming technique at the microprogram level.

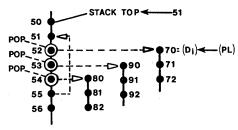


Figure 19. COND JUMP PL & POP (CJPP)

#### **Control Instruction 12**

LDCT (Load Counter and Continue) — This control instruction enables the register/counter to be loaded with the value present on the direct input lines. The direct input lines are normally connected to the pipeline register branch address field. For the architecture discussed here, the microinstruction under execution will supply either a branch address or a count value to the register/counter.

There are three methods for loading the register/counter:

- The conditional load using the PUSH control instruction (number 4).
- The use of the RLD input in conjunction with any of the control instructions.
- 3. The explicit load using LDCT.

When using  $\overline{RLD}$  in conjunction with any other control instruction, any counting or decrementing called for is overridden and a load into the register/counter occurs. The  $\overline{RLD}$  input provides additional microinstruction power at the expense of one bit of microinstruction width. LDCT is the exact equivalent of using  $\overline{RLD}$  with control microinstruction 14 (CONT). LDCT provides the ability to load the register/counter for those systems in which  $\overline{RLD}$  is not under microprogram control.

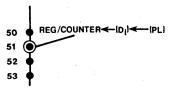


Figure 20. LD CNTR & CONTINUE (LDCT)

#### Control Instruction 13

**LOOP** (Test-End-of-Loop) — This control instruction provides a way of conditionally exiting a loop from the bottom. Prior to entering the loop, a branch address must be pushed onto the stack. LOOP will continue to branch back to the address contained on the top of the stack as long as the condition code test falls. When the condition code test passes, the next sequential address is selected ( $Y_1 = \mu AR$ ) and the stack is popped.

As shown in Figure 21, the branch address is pushed onto the stack and then the microprogram enters the loop. LOOP is located at address 56. If the condition code test fails, the branch address 52 will be taken from the stack and the program loops to address 52. If the condition code test passes, the loop will terminate and the microinstruction at the next sequential address (taken from the address register) will be executed. Address 52 is popped from the stack once the condition code test passes, thereby performing the required stack maintanance.

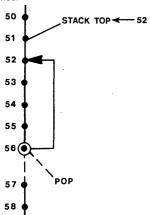


Figure 21. TEST END LOOP (LOOP)

#### **Control Instruction 14**

CONT (Continue) — This control instruction increments the address register so the next sequential micro-instruction can be executed. CONT should be the default control instruction requested by the firmware when no other control instruction needs performing.



Figure 22. CONTINUE (CONT)

#### **Control Instruction 15**

TWB (Three-Way Branch) — This control instruction is the most complex of the 16 IDM2910A control instructions. TWB is a conditional control instruction that can test either the condition code input or the register/counter contents to determine the next branch address.

A preceding control instruction, such as a PUSH, must have loaded a count value into the register/counter while pushing the loop branch address onto the stack. As long as the condition code test falls, and the register/counter is not zero, the branch will be to the address on the top of the stack and the register/counter will be decremented. If the register/counter reaches zero, the next branch address is taken from the pipeline register (via the direct input lines). If at any time during the execution of TWB the condition code passes, no branch will occur and the next sequential address will be selected ( $Y_i = \mu AR$ ). Once the loop is exited, for either reason, the stack is popped.

The three-way branch can enhance system performance in a number of ways. Some examples are:

- Performing a memory search that is terminated either by finding the desired value or by reaching the search limit.
- Terminating a variable-field-length arithmetic operation upon finding that the contents of the unprocessed portion of the field are all zeros.
- Performing a key search in a disc controller that is processing variable-length records.
- 4. Normalizing a floating-point number.

An example of a memory search operation is shown in Figure 23. A PUSH is executed at address 63 to push the return address 64 onto the stack, and to load a count value into the register/counter. The count value must be one less than the number of memory locations to be searched prior to exiting the loop. Address 64 contains a microinstruction that fetches a value from the next memory area to be searched, and compares it with the search key. A test for the results of the search comparison is at address 65. Address 65 also contains TWB for microprogram control. If matching does not occur, the condition code test fails and the microprogram loops back to address 64 to obtain the next search address. Once the register/counter equals zero, the microprogram will branch using the branch address (address 72) taken from the pipeline register. If a match is found during the search, the condition code test will pass during the TWB control instruction and the next sequential address will be taken from the address register. Regardless of which method of exiting the loop is used, the stack will be popped and the loop branch address removed from the top of the stack.

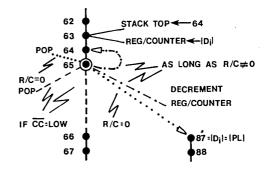


Figure 23. THREE-WAY BRANCH (TWB)

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# **Ordering Information**

Package Type	Package Number	Temperaturé Range	Order Number
Molded DIP	N40A	$0^{\circ}$ C to +70 $^{\circ}$ C	IDM2910ANC
Hermetic DIP	D40C	$0^{\circ}$ C to +70 $^{\circ}$ C	IDM2910AJC
Hermetic DIP	D40C	-55°C to +125°C	IDM2910AJM
Hermetic DIP	D40C	-55°C to +125°C	IDM2910AJM/883



# 2900 Family/ Bipolar Microprocessor

# IDM29803 16-Way Branch Controller

### **General Description**

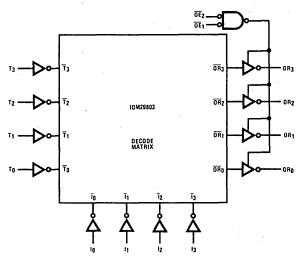
When used in conjunction with the IDM2909A address controller, the IDM29803 provides 16-way branch control. Four different inputs can be tested simultaneously by the 16 instructions of the IDM29803; thus, the four OR inputs of the IDM2909A can be driven by the four outputs of the IDM29803 and a branch can be made to any one of the 16 addresses.

If one test (T) input is being tested, the device will select one of two possible addresses; if two inputs are being tested, the device will select one of four possible addresses and, if three inputs are being tested, one of eight addresses will be selected. If all four inputs are tested, one of sixteen addresses is selected as the field used to drive the OR inputs of the IDM2909A. The "zero" instruction serves as a test inhibit function.

### Features and Benefits

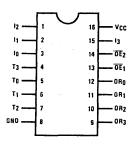
- 16 separate instructions 2-, 4-, 8-, or 16-way branch in one microprogram execution cycle
- Four discrete test inputs
- Four discrete outputs for driving the four OR inputs of the IDM2909A address controller
- Provides a maximum branching capability in a microprogram control unit using the IDM2909A
- Uses low-power Schottky technology
- Meets all requirements of MIL-STD-883

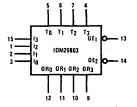
### Logic Diagram



### **Connection Diagram**

Logic Symbol





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# Absolute Maximum Ratings (Note 1)

Operating Range

P/N

Storage Temperature
Temperature (Ambient) Under Bias
Supply Voltage to Ground Potential
DC Voltage Applied to Outputs for
High Output State
DC Input Voltage
DC Output Current, into Outputs

DC Input Current

-55°C to +125°C -0.5V to +7.0V -0.5V to +V<sub>CC</sub> max -0.5V to +5.5V 30 mA

-30 mA to +5.0 mA

-65°C to +125°C

Com'l 1DM29803 DC, NC 0°C to +

0°C to +70°C 4.75V to 5.25V

VCC

Mil IDM29803 DM, DM/883 -55°C to +125°C 4.50 V to 5.50 V

Ambient

Temperature

### DC Electrical Characteristics (Note 2)

	PARAMETER	COMPLETIONS		Com'l	Mil				
	FARAWETER	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
lF	Input Load Current, All Inputs	VCC = Max, VF = 0.45V		-80	-250		-80	-250	μА
IR	Input Leakage Current, All Inputs	VCC = Max, VR = 2.7V			25			25	μΑ
IRB	Input Leakage Current, All Inputs	VCC = Max, VRB = 5.5V			1.0			1.0	mA
VOL	Low Level Output Voltage	VCC = Min, IOL = 16 mA		0.35	0.45		0.35	0.5	V
VIL	Low Level Input Voltage				0.80			0.80	V
۷ін	High Level Input Voltage		2.0			2.0			V
ICEX.	Output Leakage Current	VCC = Max, VCEX = 2.4V			50			50	μΑ
	(Open-Collector Only)	VCC = Max, VCEX = 5.5V			100			100	μΑ
٧c	Input Clamp Voltage	V <sub>CC</sub> = Min, I <sub>IN</sub> = -18 mA		-0.8	-1.2		-0.8	-1.2	٧
CIN	Input Capacitance	VCC = 5V, VIN = 2V, TA = 25°C, 1 MHz		4.0			4.0		pF
со	Output Capacitance	V <sub>CC</sub> = 5V, V <sub>O</sub> = 2V, T <sub>A</sub> = 25 °C, 1 MHz, Output "OFF"		6.0			6.0		pF
lcc	Power Supply Current	VCC = Max, All Inputs Grounded, All Outputs Open		80	130		80	130	mA
TRI-ST	ATE PARAMETERS								
¹sc	Output Short Circuit Current	VO = 0V, VCC = Max, (Note 3)	-30	-60	-100	-30	-60	-100	mA
lHZ	Output Leakage (TRI-STATE)	VCC = Max, VO = 0.45 to 2.4V, Chip Disabled			±50			±50	μΑ
۷он	Output Voltage High	I <sub>OH</sub> = -2 mA				2.4	3.2		٧
	·	1 <sub>OH</sub> = -6.5 mA	2.4	3.2					>

# AC Electrical Characteristics (With standard load)

PARAMETER		CONDITIONS		Com'l			Mil		
			MIN	TYP	MAX	MIN	TYP	MAX	
tAA	Address Access Time	(Figure 1)	10	35	50	10	35	60	ns
tEA	Enable Access Time	(Figure 2)	5	15	25	5	15	30	ns
tER	Enable Recovery Time	(Figure 2)	5	15	25	5	15	30	ns

Note 1: Absolute maximum ratings are those values beyond which the device may be permanently damaged. They do not mean that the device may be operated at these values.

Note 2: These limits apply over the entire operating range unless stated otherwise. All typical values are for V<sub>CC</sub> = 5 V and T<sub>A</sub> = 25°C.

Note 3: During ISC measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

# **Switching Characteristics Over Operating Range**

			Com'l	Mil	
Symbol	Description	Test Conditions	Min Max	Min Max	Units
tPLH	I; to OR;		50	60	ns
tPHL.	11 10 0111			00	"
tPLH	T <sub>i</sub> to OR <sub>i</sub>		50	60	ns
tPHL	1 10 0 11	Cլ = 15 pF			
tZH	OE; to OR;	R <sub>L</sub> = 2.0 kΩ	25	30	ns
tZL	02/10/01/				
tHZ	OE; to OR;		25	30	ns
tLZ	02, 0011				

#### **Definition of Functional Terms**

10, 11, 12, 13

The four instruction inputs to the device

T<sub>0</sub>, T<sub>1</sub>, T<sub>2</sub>, T<sub>3</sub>

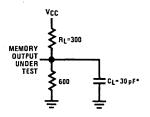
The four test inputs for the device

 $\overline{OE}_1$ ,  $\overline{OE}_2$ ,  $\overline{OE}_2$ 

The four outputs of the device that are connected to the four OR inputs of the IDM2909A Output Enable. When either  $\overline{OE}$  input is High, the OR<sub>i</sub> outputs are in the high impedance state. When both the  $\overline{OE}_1$  and  $\overline{OE}_2$  inputs are Low, the OR outputs are enabled and the

selected data will be present.

### Standard Test Load



\*CL includes probe and jig capacitance

- Input waveforms are supplied by a pulse generator having the following characteristics: PRR = 1 MHz,  $Z_{OUT} = 50 \Omega$ ,  $t_f \le 2.5 \text{ ns}$  and  $t_f \le 2.5 \text{ ns}$  (between 1.0V and 2.0V).
- tAA is measured with both enable inputs at a steady low level.
- tea and ter are measured from the 1.5V on inputs and outputs with all address inputs at a steady level and with the unused enable input at a steady low level.

# **Switching Time Waveforms**

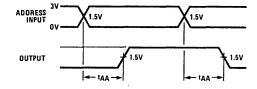


Figure 1. Address Access Time

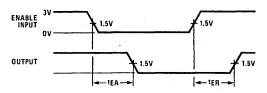


Figure 2. Enable Access Time and Recovery Time

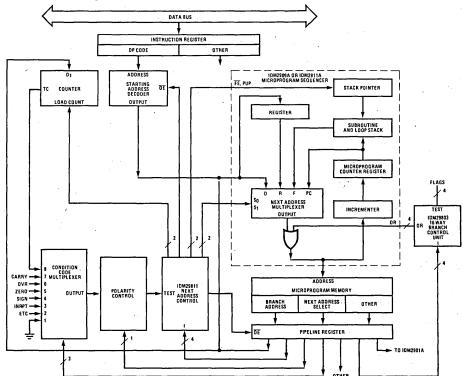
**23** 

# Guaranteed Loading Rules Over Operating Range (In Unit Loads)

A Low-Power Schottky TTL Unit Load is defined as  $20\,\mu\text{A}$  measured at 2.7V High and –0.36 mA measured at 0.4V Low.

Pin Nos.	Input/ Output	Input Load	Output High	Output Low
1	l <sub>2</sub>	0.5	_	-
2	11	0.5	-	_
3	10	0.5	_	
4	Т3	0.5	_	
5	Т0	0.5	_	
6	Т1.	0.5	-	_
7	T <sub>2</sub>	0.5	_	-
8	GND			
9	OR <sub>3</sub>	-	100	44
10	OR <sub>2</sub>	-	100	. 44
11	OR <sub>1</sub>		100	44
12	OR <sub>0</sub>	_	100	44
13	OE <sub>1</sub>	0.5	_	_
14	OE <sub>2</sub>	0.5	-	
15	l3	0.5	-	_
16	Vcc	-	-	-

# **Applications Example**



Note: The least significant microprogram sequencer is an IDM2909A and the more significant sequencers are IDM2911A's.

A Typical Computer Control Unit Using the IDM2909A, IDM2911A, IDM29803 and IDM29811.

			F	uncti	on T	able						
Function	lз	12	l <sub>1</sub>	10	Т3	T <sub>2</sub>	Τ1	То	OR <sub>3</sub>	OR <sub>2</sub>	OR <sub>1</sub>	OR <sub>0</sub>
No Test	<u> </u>	<u>L</u>	L	H	X	X	<u>X</u>	X	L	<u> </u>	<u> </u>	<u>L</u>
Test To	L	L	L	н	X	X	X	L H	L	L L	L	L H
Test T <sub>1</sub>	L	L	н	L	×	X	L H	X X	L	L	L	L H
Test To & T1	L	L	Н	н	×	Х	L	L	L	L.	L.	L
					×	× × ×	H	H L	L	L L	H	H
Test T <sub>2</sub>		Н	L	L	×	L	H X	X	L L	L	L	H L
Test To & To	L	н				H	X	X L	L	<u>L</u>	L	H
1631.10 4.12	-	••	-	••	X X X	L H	X X X	Ĥ	Ĺ	L L	Ĺ H	H
						Н		Н	L	L	Н	Н
Test T <sub>1</sub> & T <sub>2</sub>	L	Н	н	L	×	L	H	X	L	L L	L	L H
					× ×	H	H	×	L	L L	H	H
Test T <sub>0</sub> , T <sub>1</sub> , & T <sub>2</sub>	L	Н	Н	н	X	L L	L	L H	L	L L	L L	L
					X	Ĺ	H	Ë	L	Î L	Н	L H
					X	Н	Ĺ	Ľ H	L	Н Н	Ë	L H
Ì					× × × × × ×	H	H	Н	L	H	H H	L H
Test T <sub>3</sub>	Н	L	L	L.	L	×	×	×	L	L	L	L H
Test T <sub>0</sub> & T <sub>3</sub>	н	L	L	н	L			L	L	L	L	L
					H	X X X	X X X	H L	L	L L	H	H
Test T <sub>1</sub> & T <sub>3</sub>	Н	L	Н		L		X L	X	L	L	L	H
	••	-		-	i.	X X X	Ĥ	×	L	Ĺ	Ē H	H
					Н		Н	X	L	L	Н	Н
Test T <sub>0</sub> , T <sub>1</sub> , & T <sub>3</sub>	H	L	Н	н	L	X X X X X X	L L	H	L	r F	L	L H
					L	X	H	H	L	L	H	H
					H	×	L	H	L	H	L	H
					H	×	H	H	L	H	H	H
Test T <sub>2</sub> & T <sub>3</sub>	Н	Н	L	L	L L	L H	X	X	L L	L	L L	L
					H	L	× × ×	X	L	Ĺ	H	L
Test T <sub>0</sub> , T <sub>2</sub> , & T <sub>3</sub>	Н	Н	L	H	L	L		L	L	L	L	, L
					<u> </u>	H	ŝ	H L	Ŀ	L	H	H
					H	H L	×	H L	L	H	H L	H
					H	H	X X X X X X	H L	L	H	H	H ·
Test T <sub>1</sub> , T <sub>2</sub> , & T <sub>3</sub>	Н	Н	Н	L	H L	H L	- <del>`</del> L	X	L	_ <u>H</u> _	H L	H L
					L	L H	H	X	L	L	·L	H
					L	H	H		L	L	H L L	H
					H H H	L H H	L H L	X X X X	L L L	H	H	H
Test T <sub>0</sub> , T <sub>1</sub> , T <sub>2</sub> , & T <sub>3</sub>	Н	Н	Н	н	L	H_	H	L		H L	H L	<u> </u>
10, 11, 12, 0. 13	п	п	п		1	L	L	H	L L L	Ĺ	L H	H
					-	L H	H	Ĥ	Ĺ	Ĺ	H	H
					Ļ	H	F	H	L	H	Ĺ	Ä
ļ					H	H	H	H L	L	H	H	H
					H	Ĺ	L	Н	H	Ĺ	L H	H
					H	L	H L	H	H	L H	H	H
`					! н	H	L	H	H	H	L H	H
				•	H	H	H	L H ·	H	Н	Н	H

# **Ordering Information**

Package	Package	Temperature	Order
Type	Number	Range	Number
Molded DIP	N16A	0°C to +70°C	1DM29803NC
Hermetic DIP	J16A (D16C)	0°C to +70°C	IDM29803JC
Hermetic DIP	J16A (D16C)	-55°C to +125°C	1DM29803JM
Hermetic DIP	J16A (D16C)	−55°C to +70°C	IDM29803JM/883

# 2900 Family/ Bipolar Microprocessor

# **IDM29811 Next-Address Controller**

### **General Description**

The IDM29811 next-address control unit is specifically designed for next address control of the IDM2911A sequencer. The device can be used in high-performance computer control systems, structured state machine designs, or in other applications that utilize microprogramming techniques.

A 4-bit instruction field (13-10) provides sixteen instructions; also, a test input is available for conditional instructions. Among the conditional instructions that can be executed are: conditional jumps, conditional jump to subroutine, conditional return from subroutine, conditional repeat loops, conditional branch to starting address, and so on.

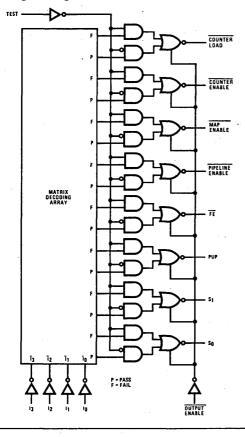
A single IDM29811 can be used to control any number of IDM2911A sequencers. Using one IDM29811 and

three IDM2911As, a sequencer capable of controlling 4k of microprogram memory can be easily implemented.

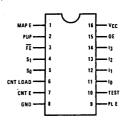
#### Features and Benefits

- 16 next-address instructions
- Test input for conditional instructions
- Separate outputs to control the IDM2911A, an independent event counter, and a mapping PROM/branch address interface
- Uses low-power Schottky technology
- Meets all requirements of MIL-STD-883

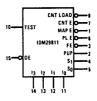
### Logic Diagram



### **Connection Diagram**



# Logic Symbol



### Absolute Maximum Ratings (Note 1)

Storage Temperature Temperature (Ambient) Under Bias Supply Voltage to Ground Potential DC Voltage Applied to Outputs for **High Output State** 

DC Input Voltage DC Output Current, into Outputs **DC Input Current** 

-65°C to +150°C -55°C to +125°C -0.5V to +6.3V

-0.5V to +VCC max -0.5V to +5.5V

30 mA -30 mA to +5.0 mA

**Operating Range** 

Ambient Temperature

**Vcc** 

Com'l

IDM29811JC,NC

0°C to +70°C

4.75V to 5.25V

IDM29811JM, JM/883

P/N

-55°C to +125°C 4.50V to 5.50V

### DC Electrical Characteristics (Note 2)

				Com'l						
	PARAMETER	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNITS	
ηL	Input Load Current, All Inputs	VCC = Max, VIN = 0.45V		-80	-250		-80	-250	μΑ	
ΊΗ	Input Leakage Current, All Inputs	VCC = Max, VIN = 2.7V			25			25	μΑ	
l <sub>l</sub>	Input Leakage Current, All Inputs	VCC = Max, VIN = 5.5V			1.0			1.0	mA	
VOL	Low Level Output Voltage	VCC = Min, IOL = 16 mA		0.35	0.5		0.35	0.5	, V	
VIL	Low Level Input Voltage				0.80	<u> </u>	İ	0.80	V	
ViH	High Level Input Voltage		2.0	<u> </u>		2.0			٧	
٧c	Input Clamp Voltage	VCC = Min, IIN = -18 mA		-0.8	-1.2		-0.8	-1.2	V	
CIN	Input Capacitance	V <sub>CC</sub> = 5V, V <sub>IN</sub> = 2V, T <sub>A</sub> = 25°C, 1 MHz		4.0			4.0		pF	
СО	Output Capacitance	V <sub>CC</sub> = 5V, V <sub>O</sub> = 2V, T <sub>A</sub> = 25°C, 1 MHz, Output "OFF"		6.0			6.0		pF	
lcc	Power Supply Current	V <sub>CC</sub> = Max, All Inputs Grounded, All Outputs Open		70	110		70	110	mA	
TRI-ST	TATE PARAMETERS									
ISC	Output Short Circuit Current	V <sub>O</sub> = 0V, V <sub>CC</sub> = Max, (Note 3)	-20	-45	-70	-20	-45	-70	mA	
lHZ	Output Leakage (TRI-STATE)	V <sub>CC</sub> = Max, V <sub>O</sub> = 0.45 to 2.4V, Chip Disabled			±50			±50	μΑ	
VOH	Output Voltage High,	I <sub>OH</sub> = -2 mA				2.4	3.2		٧	
		IOH = -6.5 mA	2.4	3.2					٧	

Note 1: Absolute maximum ratings are those values beyond which the device may be permanently damaged. They do not mean that the device may be operated at these values.

Note 2: These limits apply over the entire operating range unless stated otherwise. All typical values are for V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C.

Note 3: During ISC measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

### Switching Characteristics Over Operating Temperature

			Co	m'l	M	il	
Symbol	Description	Test Conditions	Min.	Max.	Min.	Max.	Units
tPLH	Ii to Any Output	CL = 15pF		30		40	ns
tPHL	1	$R_L = 2.0  k\Omega$					
<sup>t</sup> PLH	Test to Any Output			30		40	ns
tPHL.			1				
tZH	OE to Any Output			20		30	ns
<sup>t</sup> ZL						·	
tHZ	OE to Any Output			20		30	ns
tLZ							

### **Pinout Descriptions**

13/12/11/10

Four instruction inputs

Test

Condition-code input. When test input is low, the device assumes test has failed; when input is high, the test is assumed to have passed. In either case, a branch is made to one of the conditional-code instructions: refer to the tables which

follow.

Counter Load

An output used to drive the parallel load input of an up/down counter.

Counter Enable

An output used to drive the enable input of an up/down counter.

Map Enable

An output that controls the threestate outputs of the mapping PROM or PLA used to provide the initial starting address for each

machine instruction.

Pipeline Enable

An output used to control the three-state output of the pipeline register which contains the branch address of the computer control

unit.

FE File Enable

An output used to drive the file enable input of the IDM2911A. When this output is low, a stack operation will take place.

PUP

An output used to drive the push/pop input of the IDM2911A address controller. When the PUP output is high, a push will take place if the file is enabled. When the PUP output is low, a pop will take place if the file is enabled.

S<sub>0</sub>/S<sub>1</sub>

These outputs are used to drive the  $S_0/S_1$  inputs of the IDM2911A address controller. These outputs control whether the direct input, the register, the microprogram counter, or the stack is selected as the source of the next address for the microprogram memory.

# Instruction Table

Mnemonic	13	12	11	10	Instruction	
JZ	L	L	L	L	Jump to Address Zero	
CJS	L	L	L	Н	Conditional Jump-to-Subroutine with Jump Address in Pipeline Register	
JMAP	L	L	Н	L	Jump to Address at Mapping PROM Output	
CJP	L	L	Н	Н	Conditional Jump to Address in Pipeline Register	
PUSH	L	Н	L	L	Push Stack and Conditionally Load Counter	
JSRP	L	Н	L	Н	Jump to Subroutine with Starting Address Conditionally Selected fro IDM2911A Register or Pipeline Register	
CJV	L	Н	Н	L	Conditional Jump to Vector Address	
JRP	L	Н	Н	Н	Jump to Address Conditionally Selected from IDM2911A R-Register or Pipeline Register	
RFCT	Η.	L	·L	L	Repeat Loop if Counter is Not Equal to Zero	
RPCT	Н	L	L	Н	Repeat Pipeline Address if Counter is Not Equal to Zero	
CRTN	Н	L,	Н	L	Conditional Return-from-Subroutine	
CJPP	Н	L	Н	H	Conditional Jump to Pipeline Address and Pop Stack	
LDCT	н	Н	L	L	Load Counter and Continue	
LOOP	н	Н	L	Н	Test End of Loop	
CONT	Н	Н	Н	L	Continue to Next Address	
JP	Н	Н	Н	Н	Jump to Pipeline Register Address	

# **Function Table**

					Inputs	Outputs					
Mnemonic 13 12 11 10		Function	Test Input	Next ADDR Source	File	Counter	MAPE	PLE			
JZ	L	L	L	L	JUMP ZERO	K	D	HOLD	LL*	н	L
CJS	L	L	L	н	COND JSB PL	L H	PC D	HOLD PUSH	HOLD HOLD	H	L L
JMAP	L	L.	Н	L	JUMP MAP	×	· D	HOLD	HOLD	L	Н
CJP	L	L	Н	Н	COND JUMP PL	L H	PC D	HOLD HOLD	HOLD HOLD	H	L L
PUSH	L	Н	L	L	PUSH/COND LD CNTR	L H	PC PC	PUSH PUSH	HOLD LOAD	H H	L L
JSRP	L	Н	L.	Н	COND JSB R/PL	L H	R D	PUSH PUSH	HOLD HOLD	H H	L L
C1A	L	Н	Н	L	COND JUMP VECTOR	L H	PC D	HOLD	HOLD HOLD	H H	H
JRP	L	Н	Н	Н	COND JUMP R/PL	L H	R , D	HOLD HOLD	HOLD HOLD	H H	L
RFCT	Н	L	L	L	REPEAT LOOP, CNTR ≠ 0	L . H	F PC	HOLD POP	DEC HOLD	H	L L
RPCT	Н	L	Ŀ	Н	REPEAT PL, CNTR ≠ 0	L H	D PC	HOLD	DEC HOLD	H	L
CRTN	Н	L	Н	L	COND RTN	L H	PC F	HOLD POP	HOLD HOLD	H	L L
CJPP	Н	L	Н	Н	COND JUMP PL & POP	L H	PC D	HOLD POP	HOLD HOLD	H H	L L
LDCT	Н	Н	L	L	LOAD CNTR & CONTINUE	Х	PC	HOLD	LOAD	Н	L
LOOP	Н	Н	L	Н	TEST END LOOP	L H	F PC	HOLD POP	HOLD HOLD	H	L L
CONT	Н	Н	Н	L	CONTINUE	х	PC	HOLD	HOLD	Н	Ĺ
JP	Н	Н	Н	Н	JUMP PL	X	D	HOLD	HOLD	, н	L

L = Low H = High DEC = Decrement

\*LL = Special Case

X = Don't Care

	Truth Table													
	Pin No.	14	13	12	11	10	4	5	3	2	6	7	1	9
				Inpu	ts						Outputs		<b>,</b>	
Mnemonic	Function	l <sub>3</sub>	12	11	10	TEST				ile PUP	Cour LOAD		MAP E	PLE
JZ	JUMP ZERO	L L	L L	L	L L	L H	H	H H	H	H H	L L	L L	H H	L L
CJS	COND JSB PL	L	L	L	H	L H	L H	L H_	H L	H	H	H	H	L L
JMAP	JUMP MAP	L	L L	H	L	L H	H H	H	H	H H	H	H	L	H
СЈР	COND JUMP PL	L	L L	H	H H	L H	L H	L H	H	H	Η	H	· Н ,	LL
PUSH	PUSH/COND LD CNTR	. L L	Н	L	L	L H	L	L	L	Н	H	Н	H	L
JSRP	COND JSB R/PL	L	Н	L	Н	L H	H	H H	L	H	H	H	H	L
CJV	COND JUMP VECTOR	L	Н	Н	L	L H	H	L H	H	H	H	H	H	H
JRP	COND JUMP R/PL	L	Н	H.	H	L H	· L	H H	H	H	H H	H	H	L L
RFCT	REPEAT LOOP, CTR ≠ 0	H	L L	L L	L L	L H	H	L L	H	L L	H	L	H	L
RPCT	REPEAT PL, CTR ≠ 0	H	L	L	Н	L H	, H L	H	H	H	H	L H	H	L L
CRTN	COND RTN	H	L	Н	L	L H	L H	L L	H	L	H	Н	H	L L
CJPP	COND JUMP PL & POP	H	L L	H	H	L H	L H	L H	H L	L L	H H	H	H	L L
LDCT	LD CNTR & CONTINUE	H	H	L	L L	L H	L L	L L	H	H	. L	H	H	L L
LOOP	TEST END LOOP	H	H H	L L	Н	L. H	H	L L	H	L	H H	H	H	L L
CONT	CONTINUE	Н	H	Н	L	L H	L L	L L	H	Н	H ·	H	H	L L
JP	JUMP PL	H	Н	H	Н	L H	H	H H	H H	H	H	H	H	L

#### L = Low, H = High

# Guaranteed Loading Characteristics Over Operating Range (in unit loads)

Pin Nos.	Input/ Output	Input Load	Output High	Output Low
1	MAP E	_	100	44
2	PUP	_	100	44
3	FE	-	100	44
4	s <sub>1</sub>		100	44
5	$s_0$	_	100	44
6	CNT LOAD	-	100	44
7	CNT E	_	100	44
8	GND	· –	_	. –
9	PLE	_	100	44
10	TEST	0.5		-
11	10	0.5		-
12	11	0.5	· -	-
13	12	0.5	-	· - `
14	13	0.5	_	-
15	OE	-	100	44
16	VCC			

A Low-Power Schottky TTL Unit Load is defined as 20 µA measured at 2.7V High and -0.36 mA measured at 0.4V Low.

# 2900 Family/ Bipolar Microprocessor PRELIMINARY

# DM10900 8-Bit Parity ALU Slice

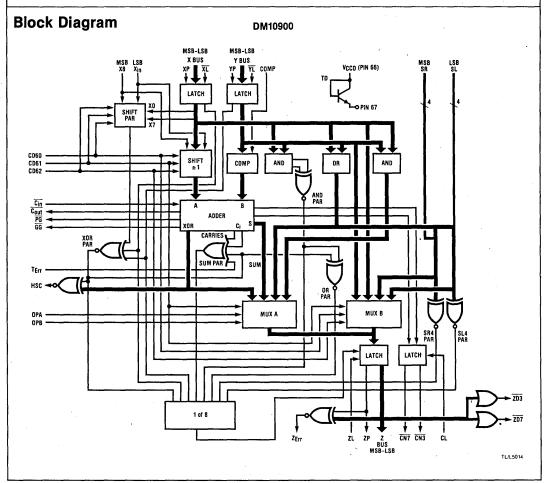
# **General Description**

The DM10900 8-Bit Microprocessor slice is a cascadable device designed for use in high performance central processing units, microprogrammable controllers, and other applications where hardware/software flexibility, ease of expansion, and ECL 10k compatibility are system requirements. The building block architecture and microinstruction format of the DM10900 permits efficient emulation of most digital systems.

As shown in the block diagram below, the DM10900 consists of a parallel 8-bit adder accessed by two latched input ports. In addition, various logic operations can also be performed on the input data. Shifting circuits and parity detect circuits implemented with ECL, oxide-isolated technology, allow the device to function as a very powerful, high performance ALU.

### **Features**

- Manufactured from high performance, oxideisolated ECL macrocell array.
- Performs all necessary logic and arithmetic operations.
- Dual port architecture two 8-bit, latched input ports; one 8-bit, latched output port.
- Internal look-ahead carry with propagate/generate outputs.
- Internal parity detect circuit with parity error output.
- Expandable in 4- or 8-bit increments to form larger word sizes.



**Test Temperature** 

Symbol	0°C	+25°C	+70°C
V <sub>IH max</sub>	-0.840	-0.810	-0.730
V <sub>IHA min</sub>	-1.145	-1.105	-1.050
V <sub>IL min</sub>	-1.95	-1.95	-1.95
V <sub>ILA max</sub>	-1.490	-1.475	-1.450
V <sub>EE</sub>	-5.2	-5.2	-5.2

(A) indicates the most positive value.

## **Recommended Operating Conditions**

 $V_{\mathsf{EE}}$  $-4.68 V_{DC}$  to  $-5.72 V_{DC}$ Supply Voltage  $(V_{CC} = 0V)$ 

Operating Temperature  $T_A$ 0 to +70°C

(Functional)

**Output Drive**  $50\Omega$  to  $-2.0V_{DC}$ 

**Junction Temperature**  $T_{1}$ 130°C Max.

## **Electrical Characteristics**

Each ECL 10,000 series circuit has been designed to meet the DC specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 1000 linear fpm is maintained. Outputs are terminated through a  $50\Omega$  resistor to -2.0V. Test procedures are shown for only one input, or for one set of input conditions. Other inputs are tested in the same manner.

		Pin			. 1	OM10900	Test Limits	;	*	·						(V <sub>CCO</sub> )
Symbol	Parameters	Under	0	°C		+25°C		+7	0°C		Volta	Voltage Applied		Voltage Applied to Pins Listed Below:		(V <sub>CC</sub> )
		Test	Min.	Max.	Min.	Тур.	Max.	Min.	Max.	Unit	V <sub>IH max</sub>	V <sub>IL min</sub>	V <sub>IHA min</sub>	V <sub>ILA max</sub>	VEE	Gnd
IEE	Power Supply Drain Current	9, 43	514	855	514	685	855	514	855	mA <sub>DC</sub>	_	_	_	_		
<sup>1</sup> INH	Input Current CD61, XL, YL, ZL, CIN, OPA	55	_	600	-	_	600	_	600	μA <sub>DC</sub>	-	. –	_	_		
	All Others	50	_	250	_	<u> </u>	- 250	-	250		50	_	_	_		:
INL		50	0.5		0.5	_	_	0.5	_	l		50	_	_		3, 15, 20
V <sub>OH</sub>	Logic High Output Voltage	4	-1.000	-0.840	-0.960		-0.810	-0.905	-0.730	V <sub>DC</sub>	50, 55, 24	31, 56, 54			9, 43	26, 60, 68
VOL	Logic Low Output Voltage	4	-1.95	-1.665	-1.95	_	-1.650	-1.95	-1.625	V <sub>DC</sub>	55, 24	50, 31, 56, 54	_	_		
V <sub>OHA</sub>	Logic High Threshold Voltage	4	-1.02	-	-0.980	. =	_	-0.925	_	V <sub>DC</sub>	55, 24	31, 56, 54	50	_		
VOLA	Logic Low Threshold Voltage	4	_	-1.645	-	_	-1.630	-	-1.605	V <sub>DC</sub>	24, 55	31, 54, 56		50		



#### DM10900

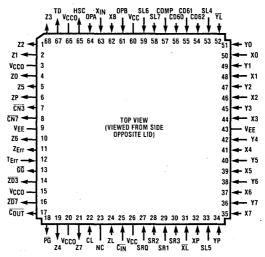


FIGURE 1. Input/Output Diagram

TL/L5014

#### DM10900 Grid Array Package Drawing Not Available at This Time

Table 1. Pin Assignments

Pin Description	Pin Number	Description
X0	50	Input Bus - LSB Input
X1	48	Input Bus
X2	46	Input Bus
X3	44	Input Bus
X4	41	Input Bus
X5	39	Input Bus
X6	37	Input Bus
X7	35	input Bus — MSB Input
X8	62	Shift Interconnect—MSB
XL	31	X Latch Control Bit
XP	32	X Input Parity Bit
X <sub>IN</sub>	63	Shift Interconnect—LSB
Y0	51	Input Bus LSB Input
Y1	49	Input Bus
Y2	47	Input Bus
Y3	45	Input Bus
Y4	42	Input Bus
Y5	40	Input Bus
Y6	38	Input Bus
Y7	36	Input Bus MSB Input
YL	52	Y Latch Control Bit
YP	34	Y Input Parity Bit
CIN	25	Carry Input
Cout	17	Carry Output
PG	18	Group Propagate Output
GG	13	Group Generate Output
C <sub>n</sub> 3	7	Detect System Overflow
C <sub>n</sub> 7	8 .	Detect System Overflow
SR0 27		Shift Right Input to Z4
SR1	29	Shift Right Input to Z5
SR2	28	Shift Right Input to Z6
SR3	. 30	Shift Right Input to Z7
SL4	53	Shift Left Input to Z0
SL5	33	Shift Left Input to Z1

Pin Description	Pin Number	Description
SL6	59	Shift Left Input to Z2
SL7	58	Shift Left Input to Z3
. Z0	4	Output Bus — LSB Output
Z1	2	Output Bus
Z2	1	Output Bus
Z3	68	Output Bus
Z4	19	Output Bus
Z5	5	Output Bus
Z6	10	Output Bus
<u>Z7</u>	21	Output Bus — MSB Output
ZD3	14	Zero Detect
ZD7	16	Zero Detect
ZP ´	6	Parity Detect Output
ZL	24	Z Latch Control Bit
Z <sub>Err</sub>	11	Bus Error Detect Output
T <sub>Err</sub>	12	Test Error Input
Comp	57	Control Input Complement
CD60	56	Control Input
CD61	55	Control Input
CD62.	54	Control Input
HSC	65	Half Sum Check Output
OPA	64	Control Input
OPB	61	Control Input
VEE	. 9	-5.2 Volt Supply
V <sub>EE</sub>	43	-5.2 Volt Supply
V <sub>CC</sub>	26	Ground
V <sub>CC</sub>	60	Ground
Vcco	3	Ground
V <sub>cco</sub>	15	Ground
V <sub>cco</sub>	20	Ground
Vcco	66	Ground
CL	22	Carry Latch Enable
NC	23	Not Used
TD	67	Test Diode

### Operation

The basic data input ports to the DM10900 are the X bus and Y bus, each capable of accepting eight data bits. To expand the word size of a DM10900 system, single-bit data paths  $C_{\text{IN}}$ ,  $C_{\text{OUT}}$ ,  $X_{\text{IN}}$ , and X8 along with 4-bit paths SL and are provided. In addition, group propagate and group generate outputs can be used with external carry lookahead logic in an expanded system for faster operation.

The DM10900 outputs data on the Z bus and provides zero detect signals  $\overline{\text{ZD7}}$  for outputs  $\overline{\text{Z7-Z4}}$  and  $\overline{\text{ZD3}}$  for outputs  $\overline{\text{Z3-Z0}}$ . In addition, carry signals  $\overline{\text{CN3}}$  and  $\overline{\text{CN7}}$  are generated within the adder for determining overflow conditions. Parity circuitry continuously monitors data flow within the ALU slice and provides two error signals.

Each input and output port consists of eight data bits and one odd parity bit. The two input ports are latched and routed to four logic networks which generate a 1-bit shift right or left of X, a complement of Y, a logic OR of X and Y, and a logic AND of X and Y. The shift and complement circuits input to the adder network which provides the arithmetic sum and the logic exclusive-OR. Two 1-of-4 multiplexers select the data path to the Z output bus.

## **Pin Descriptions**

- X Input Bus. These eight data input pins serve as data paths to an internal latch in the ALU. Data is passed through the latch when Latch Control bit, XL, is brought low and latched when XL is brought high. X7 is the most significant bit (MSB) of the X input bus.
- Y Input Bus. These eight data input pins operate identically to the X input bus described above. YL is the latch control signal for the Y input bus.
- Parity Inputs, XP and YP. To utilize the parity detect circuitry of the DM10900, parity for X input data and Y input data should be entered on the XP and YP inputs respectively. These bits are used in determining the Z parity output, ZP, and parity error signals, HSC and Z<sub>Err</sub>.
- Shift Interconnects. Shift interconnect signals X<sub>IN</sub>, X8, SL and SR are provided to facilitate shift operations in cascaded slice systems.

For a single-bit shift left,  $X_{\rm IN}$  is shifted into the X0 position and for a single-bit shift right, X8 is shifted into the X7 position. SL and SR are used for 4-bit shifts. For a shift left, SL7–SL4 are shifted into Z3–Z0 respectively, while the results of the OR circuit,  $(X+Y)_3-(X+Y)_0$  are shifted into Z7–Z4, respectively. For a shift right, SR3–SR0 are shifted into Z7–Z4, respectively, while the OR circuit outputs  $(X+Y)_7-(X+Y)_4$  are shifted into Z3–Z0, respectively.

5. Half Sum Check. HSC is a parity check of the X bus and Y bus along with an error check of the half sum adder network. HSC will detect a single-bit error or any combination of odd number of errors. Half sums are derived from the bit-by-bit Exclusive-QR of the two busses. The half sum bits, along with the input parity bits XP and YP, determine HSC as follows:

HSC = HS7 + GS6 + HS5 + HS4 + HS3 + HS2 + HS1 + HS0 + XP + YP + Shift PAR

 Carry Signals. System overflow can be detected by the carry signals CN3 and CN7. Overflow occurs when the maximum system word or byte value has been exceeded. Only the overflow from the most significant 8-bit slice is used in a typical system.

Overflow is detected by the exclusive-OR of the carry out and carry in of the most significant bit in a system. In an 8-bit increment system (8, 16, 24, etc.) overflow can be generated by the exclusive-OR of  $\overline{C}_{OUT}$  and  $\overline{CN7}$ . In a 4-bit increment system (4, 12, 16, etc.) overflow can be generated by the Exclusive-NOR of Z4 and  $\overline{CN3}$  (OF = Z4+ $\overline{CN3}$ ). Z4 is effectively the carry out of the 8-bit slice operating in a 4-bit slice mode.

Carry in,  $\overline{C_{\text{IN}}}$ , is used to interconnect 8-bit slices in a system. In a ripple carry mode,  $\overline{C_{\text{IN}}}$  is connected to the carry out,  $\overline{C_{\text{OUT}}}$ , of the previous slice.  $\overline{C_{\text{OUT}}}$  occurs when the calculated value within the ALU exceeds the maximum capacity, a binary count over 255.  $\overline{C_{\text{OUT}}}$  is generated by look-ahead carry logic in the 8-bit ALU.

- Output Z Bus. These eight data output pins connect the output data latch to the external system. Data passes through the latch to the Z bus when ZL is high. Z7 is the most significant output bit.
- 8. Zero Detect. ZD7 and ZD3 indicate all lows on output latch Z7-Z4 and Z3-Z0, respectively. These outputs go low when their corresponding output bits are all low.
- Z Bus Error. Z<sub>Err</sub> indicates a single-bit error (or odd number of multiple errors) in data flowing through the multiplexers or output latch. The output parity bit, ZP, is compared with the parity of the Z bus output generating a logic high on Z<sub>Err</sub> if an error exists.

 $Z_{Err}$  can be tested with the test error input,  $T_{Err}$ , when an arithmetic operation is performed. When enabled, a logic high on  $T_{Err}$  will result in an incorrect parity of the arithmetic operation output Sum. This will be detected by the Z bus error logic as shown in the block diagram.

 Parity Output. ZP is used to output the parity of the Z bus. It is generated independently of the Z bus, which adds another level of system error check.

ZP is the Exclusive-OR of the selected function before multiplexing onto the Z bus. For example, if the ALU were performing an AND operation, ZP would be:

 $ZP = XY7 \oplus XY6 \oplus XY5 \oplus ... \oplus XY0$ 

- 11. Group Propagate/Generate. Group propagate, PG, and group generate, GG, are used as inputs to external look-ahead carry logic for carry in signals that can be obtained with faster ripple techniques. The propagate output goes low when the maximum value occurs on the ALU outputs (255). Group generate occurs with a value of 256 or greater. These signals are useful only with arithmetic operations.
- 12. **Test Diode.** A test diode, TD, is connected to Pin 67 for use in measuring junction temperature. Pin 66 is the diode anode; Pin 67 the diode cathode.

## **Select Line Operation**

#### **One-Bit Shift Select**

Control inputs CD60, CD61, and CD62 are used to give the ECL8-bit slice a 1-bit shift left or a 1-bit shift right. A logic L on CD62 results in a 1-bit shift left whereas a logic H results in a 1-bit shift right operation. When CD60 is held at a logic L or CD61 is held at a logic H, no shift operation is performed. Table 2 illustrates the 1-bit shift operation.

Table 2

Operation	CD60	CD61	CD62
No Shift	L	Х	Х
No Shift	X	Н	X
1-Bit Shift Left	Н	· L	L
1-Bit Shift Right	Н	Ì.	Н

#### Mux B Select

Control inputs CD60, CD61, and CD62 are used to select the data path to the ALU output latch. When CD61 is held at a logic H, Mux B is enabled. CD60 and CD62 select ALU functions pass X, pass Y, shift left four bits or shift right four bits. (See Table 3.)

Table 3

Function	ZP	CD61	CD60	CD62
Not Enabled	See Table 4	L	Х	Х
Pass X	XP	Н	L	L
Pass Y	YP	Н	L	Н
Shift Left 4 Bits	SL4 PAR	Н	н	L
Shift Right 4 Bits	SR4 PAR	Н	Н	Н

SL4 PAR = [SL4⊕SL5 SL6⊕SL7]⊕

 $[(X0 + Y0) \oplus (X1 + Y1) \oplus (X2 + Y2) \oplus (X3 + Y3)]$ 

SR4 PAR = [SR0 + SR1 + SR2 + SR3] +

 $[(X4 + Y4) \oplus (X5 + Y5) \oplus (X6 + Y6) \oplus (X7 + Y7)]$ 

#### **Mux A Select**

Control inputs OPA, OPB, and CD61 are used to select the data path to the ALU output latch. When CD61 is held at a logic L, Mux A is enabled, OPA and OPB select ALU functions Sum, XOR, X + Y, or X • Y (see Figure 11). See Table 4.

Table 4

Function	ZP	CD61	OPA	ОРВ
Not Enabled	See Table 3	Н	X	χ.
Sum	Sum PAR	L	L	L
XOR	XOR PAR	L	L	Н
X•Y	AND PAR	L	н	L
X + Y	OR PAR	L	н	Н

XOR PAR = (Shift PAR) (XP+YP) where

Shift PAR = [X7 + X1N) • CD62 + (X8 + X0) •

CD62] • CD60 • CD61 AND PAR = [(X0 • Y0) ⊕ (X1 • Y1) ⊕ (X2 • Y2) ⊕

(X3 • Y3)]⊕[(X4 • Y4)⊕(X5 • Y5)⊕

. (X6 • Y6)⊕(X7 • Y7)]

OR PAR = (AND PAR) (XOR PAR)

Sum PAR = CIN + C1 + C2 + C3 + C4 + C5 +

C6+C7+TErr+(XOR PAR)

where  $C_{\mbox{\footnotesize{IN}}}$  is the carry-in for generating bit  $Z_{\mbox{\footnotesize{I}}}$  for  $\mbox{\footnotesize{I}}=1$  to 7.

#### Complement Y Select

Control input Comp inhibits or enables the complement operation. When Comp is at a logic L, Y data is passed. When Comp is at a logic H, Y is complemented.

Table 5

Operation	Comp
Pass Y	Ļ
Complement Y	Н

Table 6

Function	ZP	CD61	CD60	CD62	OPA	OPB	Comp
X+Y+C <sub>IN</sub>	Sum PAR	L	L	Х	L	L	L
X+YeC <sub>IN</sub>	Sum PAR	L	L	x	L	L	н
X⊕Y	XOR PAR	. L	L	×	L	Н	L
X⊕₹	XOR PAR	L	L	X	L	н	н
XSL+Y+C <sub>IN</sub>	Sum PAR	L	Н	· L	L	L	L
XSL+T+CIN	Sum PAR	L	н.	L	L	L	н
XSL⊕Y	XOR PAR	L	н	L	L	н	L
XSL⊕Ÿ	XOR PAR	L	н.	L	. L	Н	н
XSR+Y+C <sub>IN</sub>	Sum PAR	L	Н	Н	L	L	L
XSR+Y+CIN	Sum PAR	L	Н	Н	L	L	н
XSR⊕Y	XOR PAR	L	н	н	L	н	_ L
XSR⊕Ÿ	XOR PAR	L	н .	Н	L	н	Н
X • Y	. AND PAR	L	×	×	Н	L	x
X+Y	OR PAR	L	x	x	н	н	x .
x	XP	н	L	L	×	×	X.
Y	, YP	н	Ĺ	н	×	×	x
Shift Left Four Bits1	SL4 PAR	H	н .	L	x	X	x
Shift Right Four Bits <sup>2</sup>	SR4 PAR	н	Н	H-	X	X	. x

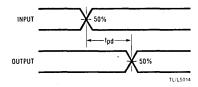
- 1. The least significant four bits of X or Y are shifted into the most significant four bits. The four least significant bits are replaced with SL7-SL4 inputs.
- 2. The most significant four bits of X or Y are shifted into the least significant four bits. The four most significant bits are replaced with SR3-SR0 inputs.

  + Logic Inclusive-OR.

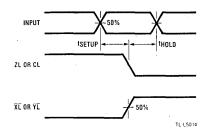
   Logical AND.

   Logical Exclusive-OR.

# Switching Waveforms Propagation Delays



#### Setup and Hold

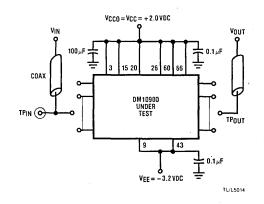


#### Setup and Hold

Test Procedure:

- a. Establish setup time with long thold.
- b. Keeping the leading edge of the input constant (t<sub>setup</sub>), vary the trailing edge of the input to determine thold.

# Switching Time Test Circuit $V_{CCO} = V_{CC} = +2.0 V_{DC}$



 $50\Omega$  termination to ground location in each scope channel input.

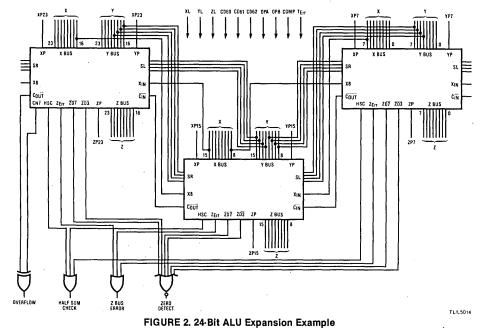
All input and output cables to the scope are equal lengths of  $50\Omega$  coaxial cable. Wire length should be < 1/4inch from TP<sub>IN</sub> to output pin and TP<sub>OUT</sub> to output pin.

### Setup and Hold Times (Nanoseconds) 0 to +70°C TA (TJ not to exceed +115°C)

Input	Clock (Ref. Edge)	Output	Setup (Min.)	Hold (Min.)
X Bus, XP	XL (L→H)	All	1.6	+1
Y Bus, YP	YL (L→H)	All	1.6	+1
X Bus, Y Bus, Comp.	ZL (H→L)	Z Bus	17.8	0
	ZL (n ~L)	ZP	19.2	0
	CL (H→L)	CN3, CN7	14.5	0
XP, YP	ZL (H→L)	ZP	11.7	0
C <sub>IN</sub>	ZL (H→L)	Z Bus	12	-1
	ZE (11 · E)	ZP	14.3	-1
	CL (HB→L)	CN3, CN7	8.6	-1
SL, SR	ZL (H→L)	Z Bus	6.1	+0.5
	ZL ((1 * L)	ZP	12	0
X8, X <sub>IN</sub>	ZL (H→L)	Z Bus	. 15.5	-1
	22 (11 2)	ZP	17.2	-1
	CL (H→L)	CN3, CN7	12.1	-1
OPA, OPB	ZL (H→L)	Z Bus, ZP	10.6	+0.5
CD60, CD61, CD62	ZL (H→L)	Z Bus	24.2	+0.5
	ZL (11 · L)	ZP	26.1	0
	CL (H→L)	CN3, CN7	21.1	-1
XL, YL (H→L Edge)	ZL (H→L)	Z Bus	18.9	-0.5
	ZL (11 · L) \	ZP	20.4	-1
	CL (H→L)	CN3, CN7	15.5	-1
T <sub>Err</sub>	ZL (H→L)	ZP	7	0

### Propagation Delay (Nanoseconds)

Input	)	Pa	ath	Output	U to 70°C TA (TJ n	not to exceed 115°)	
input		Via	Mode	Mode		Maximum	
X Bus		Adder	XOR	Z Bus	Typical 7.9	12.2	
Y Bus	l	Adder	Arith.	Z Bus	11.6	17.8	
Comp	i	Mux B	Logical	Z Bus	6.8	10.8	
	I	Adder	Arith.	ZP	12.5	19.2	
		Addoi	7.11.11.				
				C <sub>OUT</sub> CN3, CN7	7.5	11.5	
	١ ١			CN3, CN7	9.4	14.4	
				ZD7, ZD3	13.9	20.7	
	- 1		•	HSC	9.8	15.1	
	- 1			7.	16.7	25.7	
				Z <sub>Err</sub> PG			
	. 1			PG PG	7.5	11.5	
	l			GG	7.4	11.3	
XP			· · · · · · · · · · · · · · · · · · ·	ZP	7.6	11.7	
ΥP				HSC	6.8	10.4	
	1			Z <sub>Err</sub>	10.5	16.2	
C <sub>IN</sub>	1	Adder	Arith	Z Bus	7.8	12	
	ļ			ZP	9.3	14.3	
				C <sub>OUT</sub>	2.8	4.3	
	j			CN3, CN7	5.5	8.5	
				<u> </u>			
	1			ZD7, ZD3	10	15.3	
	1.0		.,	Z <sub>Err</sub>	12.3	18.9	
<u></u>		MuyD	Shift 4 Bits	Z Bus	4		
SL	}	MuxB	Smit 4 Bits		1 I	6.1	
SR	1			<u> ZP</u>	7.8	12	
				ZD7, ZD3	6.3	9.7	
X8		Adder	Shift 1 Bit	Z Bus	10.1	15.5	
<b>^</b> 0		Adder	SHILLIBIL				
				ZP	11.2	17.2	
X <sub>IN</sub>				C <sub>OUT</sub>	6	9.2	
			*	CN3, CN7	7.8	12	
				707 700	12.3	18.9	
	j			ZD7, ZD3			
	1			PG	6	9.2	
	- 1			GG	5.8	8.9	
	- 1			HSC	8.6	13.2	
	1				15.5	23.8	
		·		Z <sub>Err</sub>			
T <sub>Err</sub>	J		Z Parity	ZP	4.5	· <b>7</b>	
	1		Error Check	Z <sub>Err</sub>	7.5	11.5	
XL YL	i	Latch	Latch X, Y	Z Buş	12.3	18.9	
Ϋ́L	Į			ZP	13.3	20.4	
				C <sub>OUT</sub>	8.3	12.7	
	- 1			CN3 CN7			
				<u>CN3, CN7</u>	10	15.4	
	· '			ZD7, ZD3	14.5	. 22	
	- 1			HSC	10.5	16.2	
	l	*		Z <sub>Err</sub>	17.4	26.8	
	-		i	PG	8.2	12.6	
	ŀ						
·	1	·		GG	8.1	12,4	
OPA		Mux A	Select	Z Bus	6.9	10.6	
OPB	1	max A	20.000	ZP	5.9		
OFB	I					9.1	
	l			ZD7, ZD3	9.4	14.4	
	i			Z <sub>Err</sub>	11.4	17.5	
CDGO		V 44 4 4 4	Chift 4 Dia				
CD60	i	Adder	Shift 1 Bit	Z Bus	15.7	24.2	
CD61	1			<u>ZP</u>	17	26.1	
CD62		-		Соит	11.6	17.9	
-				CN3, CN7	13.7	21	
	l	-		707 700		07.7	
				ZD7, ZD3	18	27.7	
				HSC	14.4	22.1	
	- 1			Zerr	21.3	32.7	
	1	'	,	Z <sub>Err</sub> PG	12	18.5	
				🔀	14		
				ĞĞ	11.9	18.3	
ŽL		Latch	Latch Z	Z Bus, ZP	3.3	5	
<u></u>		Laten	Lawii				
				ZD7, ZD3	5.5	8.7	
				Z <sub>Err</sub>	7	11.6	
CL		Latch	Arith	CN3, CN7	2.8	4.3	
		Laten	AHIN	ı UNS. UN/	. 25 1	4.3	





**Applications** 

# IDM2900 Family Applications Information



#### SYSTEM ARCHITECTURE OF THE IDM2901A

The IDM2901 is designed for use in microprogrammed systems; figure 1 illustrates a typical configuration for such a system. All devices use a common clock while two registers provide control signals and data inputs to the CPU. One of the registers serves as a direct-data input to the device, whereas the other register provides a communications link between the 2901, the microprogram sequencer, and the microprogram storage device (RAM, ROM or PROM). The "memory store" device contains microinstruction sequences, typically 28 to 60 bits wide. When selected, these microinstructions control the IDM2901 and other circuits in order to execute the chosen operation. Address lines of the "store" device are driven by the microprogram sequencer. The sequencer can store an address, incre-

ment an address, jump to any address, and link subroutines. Control bits for the "next instruction" originate in the "microprogram store." This arrangement plus the fact that the control register is between the storage device and the 2901 means that the instruction can be accessed on one cycle and executed on the next cycle. In summary, as one instruction is executed, the next instruction is being read from microprogram memory. In such a configuration, system speed is improved because "access time" and "execution time" occur in parallel; without the "pipeline instruction register," these two operations would be implemented in serial order. Other speed-enhancement techniques are detailed later under "Speed Enhancement of Bipolar Bit-Slice Microprocessor Systems."

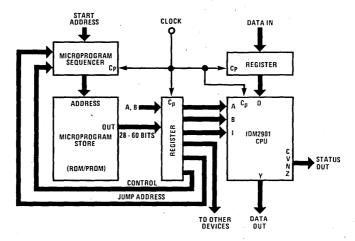


Figure 1. Microprogrammed System Using the IDM2901

# EXPANDING THE IDM2901 BIT-SLICE MICROPROCESSOR

The IDM2901 is a 4-bit slice microprocessor; thus, any number of devices can be interconnected to produce, in 4-bit increments. CPUs of 8, 12, 16, 24, 36, or more bits. Figure 2 shows how three devices can be connected to form a 12-bit CPU using ripple carry; figure 3 shows a 16-bit CPU using carry look-ahead, and figure 4 shows the general carry look-ahead scheme for long words.

With exception of the carry interconnections, all expansion schemes are the same. The Q<sub>3</sub> and RAM<sub>3</sub> pins provide bidirectional left/right functions for the most

significant bit. Except for the last device in the string, the Q3 and RAM3 lines connect, respectively, to the Q0 and RAM0 lines of the next device. These connections permit the "Q" register of each device to be shifted left or right as a contiguous n-bit register; also, it allows output data from the ALU to be shifted left or right as a contiguous n-bit word prior to storage in RAM. As shown in the single-slice configuration (see figure 5), the shift lines at the LSB and MSB could be connected to the TRI-STATE multiplexer; the multiplexer can then be controlled by microcode to select appropriate shift-input signals.

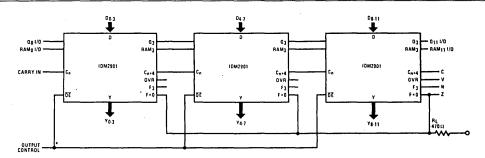


Figure 2. 12-Bit CPU with Ripple Carry

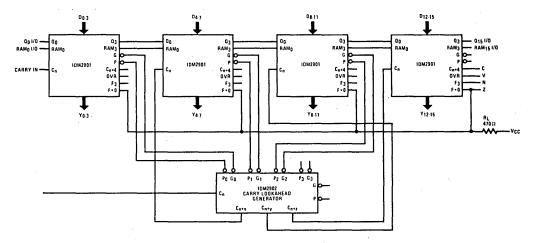


Figure 3. 16-Bit CPU Using Carry Lookahead

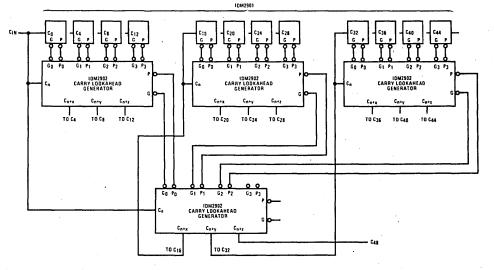


Figure 4. 48-Bit CPU Uşing Multiple Carry Lookahead

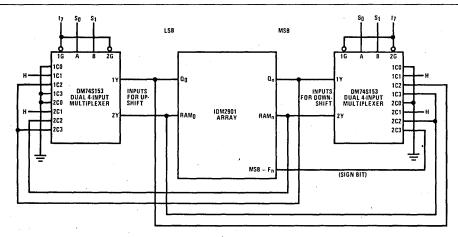


Figure 5. Typical Input/Output Shifting at End of Array

All "F=0" outputs are connected together through a pull-up resistor; this line is high only if the ALU contains all zeroes. Most systems use the "F=0" line as a "0" flag input to the processor status word. The overflow and F3 pins are meaningful only when twos complement signed arithmetic is used. The overflow (V) output is high when the result of an arithmetic operation is a number requiring more bits than are available, causing the sign bit to be erroneous. The F3 (MSB of ALU output) is the sign of the result in twos complement notation and indicates the negative (N) bit of the processor status word. The carry (C) bit of the status word is taken from the most significant processor (D12-D15, figure 3) in the string; carry interconnections between devices can use either ripple carry or carry look-ahead. For ripple carry, the carry-out (Cn+4) of each device is connected to the carry-in (Cn) of the next most significant device; for example, Cn+4 of device Do-D3 connects to Cn of D4-D7, Cn+4 of D4-D7 connects to Cn of D8-D11, and so on for all interconnected devices.

As shown in figure 5, during shifting, TRI-STATE multiplexers are used to select new input information for the "Q" register and RAM; the left/right shift data is transferred between devices over bidirectional lines. Figure shows how two dual 4-input multiplexers can be connected to provide four shift modes; in this case, 17 (from the IDM2901A) is used to select the up-shift or down-

shift multiplexer. In this example, the four shift modes are defined below; these are followed by a table that provides an operating summary.

Zero On a down-shift, the MSB of RAM is set low (logic 0); if the Q register is also shifted, the MSB of this register is likewise set low. For an up-shift, the LSB of the affected register(s) is set low.

One Same as preceding description for "zero," except the MSB or LSB is set high (logic 1) rather than low (logic 0).

Rotate Single precision rotate — MSB of RAM shifts into LSB on a right shift; LSB shifts into MSB on a left shift. If shifted, the Q register bits are shifted in the same manner.

Arithmetic

Double-length arithmetic shift provided the Q register is also shifted. On an up-shift, a "zero" is loaded into the LSB of the Q register and the MSB of the Q register is loaded into the LSB of RAM. On a downshift, the LSB of RAM is loaded into the MSB of the Q register and the MSB (Fn = sign bit) of the ALU output is loaded into the MSB of RAM. (The same bit will also appear in the next least significant RAM

	Code	)		Source of New Data			Shift	T
17	S <sub>1</sub>	s <sub>0</sub>	$\sigma_0$	Qn	RAM <sub>0</sub>	RAMn	Silit	Туре
Н	L	L	. 0	Q <sub>n-1</sub>	0	F <sub>n-1</sub>	Up	Zero
Н	L	Н	1	Q <sub>n-1</sub>	1	F <sub>n-1</sub>	(Right)	One
н	Н	L	Qn	Q <sub>n-1</sub>	Fn	F <sub>n-1</sub>		Rotate
Н	Н	Н	0	$Q_{n-1}$	Q <sub>n</sub>	F <sub>n-1</sub>		Arithmetic
L	L	L	01	0	F <sub>1</sub>	0	Down	Zero
L	L	н	Ω <sub>1</sub>	1	∘F₁ ·	1	(Left)	One
L	Н	L	Q <sub>1</sub>	$\alpha_0$	F <sub>1</sub>	F <sub>0</sub>		Rotate
ᆫ	H	Н	Ω <sub>1</sub>	Fo	F <sub>1</sub>	$RAM_n = RAM_{n-1} = F_n$		Arithmetic

#### HARDWARE MULTIPLICATION

In its simplest form, interconnection for an 8-bit by 8-bit multiplication is shown in figure 6. This configuration can be easily expanded to 12 bits, 16 bits, or more by simply making the proper connections at the LSB and MSB of each device in the chain. The scheme shown in figure 6 uses the "add-and-shift" technique; thus, one clock cycle is required for each bit of the multiplier. For each clock cycle, the LSB of the multiplier is examined; if the bit is high (logical 1), the multiplicand is added to the partial product to generate a new partial product. The "new" partial product (or multiplicand) is then shifted one position towards the LSB and the multiplier is shifted in the same manner. The "old" LSB of the multiplier is discarded and the cycle is repeated until each bit of the multiplicand is used to generate a partial product. After each bit-operation is completed, the "new" LSB of the multiplier is available at Qo.

The multiplier is retained in the Q register of the IDM2901 and the multiplicand is held in one of the file registers (Ra); the partial product is developed in yet another file register (Rb). The A-address field inputs (figure 1) are used to address the multiplicand in  $R_a$ ; the B-address field is used to address the partial product, which resides in  $R_b$ . On each cycle, the contents of  $R_a$  are conditionally added to the contents of  $R_b$  and, depending on the LSB of the Q register as read from the  $Q_0$  output, both the Q-register and the ALU result are shifted one position left. The microinstruction lines for each cycle of the operation are as indicated.

18/17/16 = 4 (left-shift register file input and Q register) 15/14/13 = 0 (add)

 $I_2/I_1/I_0 = 1$  or 3 (select A/B or O/B as ALU sources)

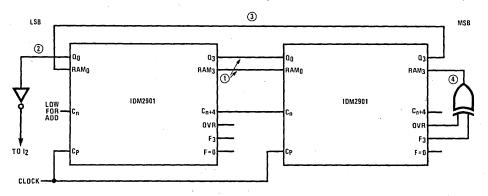


Figure 6. Using Two IDM2901s for 8-bit by 8-Bit Multiply

The circled numbers in figure 6 refer to steps in the multiplication summary that follows.

- Input and output pins of the Q register and RAM are connected such that the Q register of each 2901 device can be left or right shifted in unison. Likewise, an 8-bit (or n-bit) ALU can be shifted as one integral unit prior to storage in the register file.
- 2. Source operands of the ALU are determined by the LSB output of the Q register; these operands are: A/B (add multiplicand to partial product) or 0/B (add nothing to partial product). Microinstruction bit l<sub>1</sub> can select between the operands (A/B or 0/B); bit l<sub>1</sub> can be directly driven from the LSB-complement of the multiplier.
- 3. When the "new" partial product appears at the input of the register file, it is shifted left by the RAM shifter. The LSB of this "new" product is complete and is not affected by future operations; accordingly, it is output at RAMo, where it is then input to the MSB of the O register. As each cycle is completed, the LSB of the product is input to the MSB of the

- Q register; thus, when the operation is completed, the Q register contains the least significant half of the resulting product.
- 4. As the ALU output is down-shifted for each clock cycle, the sign bit of the new partial product is input to the MSB of the RAM shifter. If overflow has not occurred, the F3 flag will correctly designate the sign. If an overflow has occurred, the overflow (OVR) output is set high and, in this case, the correct sign is the complement of F3, that is, F3. In summary, the correct sign bit to be shifted into the MSB of the partial product is F3 (no overflow) or F3 (with overflow). On the last cycle, when the MSB of the multiplier is examined, a conditional subtraction is performed this is because the sign bit of the multiplier carries negative rather than positive arithmetic weight:

$$(Y = -Y_i 2^i + Y_{i-1} 2^{i-1} + ... + Y_0 2^0)$$

The foregoing scheme will correctly produce a twos complement product for all multiplicands and multipliers in twos complement notation. Figure 7 shows the input states of the IDM2901s for each step of a signed, twos complement multiplication.

#### **Initial Register States**

R

0 Multiplier

1 Multiplicand

2 X

3 X

#### **Final Register States**

R
0 Multiplier
1 Multiplicand
2 LSH Product
3 MSH Product

S, F →	D	Description	Repeat		Pin States (Octal)											
3, F →	Ù	Description	nepeat	Α	В	1876	1543	<sup>1</sup> 210	Cn	$\sigma_0$	Ω3	RAM <sub>0</sub>	RAM3	То	If	
OVA	Q	Move Multiplier to Q	_	0	Х	0	3	4	x	Х	х	×	х			
ОВ	В	Clear R <sub>3</sub>	-	х	3	2	4	3	x	Х	х	Х	х			
(O+B)/2 (A+B)/2	I R	Cond. Add & Shift	n-1	1	3	4	0	$1 \text{ or } 3$ $I_1 = \overline{Q_0 LO}$	0	_	RAM <sub>0</sub>	_	F <sub>3</sub> V OVR			
(B-O)/2 (B-A)/2	- 14	Cond. Subt. & Shift	-	1	3	4	1	1 or 3 I <sub>1</sub> = Q <sub>0</sub> LO	1	-	RAM <sub>0</sub>	_	F <sub>3</sub> V OVR			
ονο	В	Move LSH Prod. to R <sub>2</sub>	_	Х	2	2	3	2	x	х	х	Х	X			

X = Don't Care

F = Function

D = Destination

Figure 7. Twos Complement Multiplication

S = Source

#### BYTE SWAPPING

Sometimes it is expedient or necessary to swap the two halves of a 16-bit word — interchange D<sub>0.7</sub> with D<sub>8.15</sub> and vice versa. A fast method of implementing the swap is to rotate the word in RAM, shifting 2 bits at a time — only four shift cycles are required. The same file register is selected at both A and B ports; these two values are added together with carry-in connected to carry-out, producing a single position shift to the right. The ALU is then shifted to the right one more position prior to storage in RAM. For example, the byte swap of R<sub>0</sub> would be implemented by repeating the following set of conditions four times:

A = B = 0; I = 701;  $RAM_0 = RAM_{15}$ ;  $C_{IN} = C_{OUT}$ 

#### INSTRUCTION FETCH CYCLE

Generally, execution of a microinstruction begins with an instruction fetch cycle. The address of the instruction to be fetched (and executed) is held in the program counter (PC) and, as the first step, this address must be put in the memory address register. Next, the PC is incremented to point to the next instruction. The instruction obtained from memory is loaded into the program sequencer, which causes a jump to the microcode that executes that particular instruction. The PC can be read out and incremented in one cycle by using destination code "2" and addressing the PC with both the A and B fields. The current value of PC will appear on the Y outputs and (PC+1) will be returned to the register. For example, if PC is in register 15:

A = B = 15; I = 203; Carry-in = 1

The PC contents will appear at the Y outputs via the A port of RAM. On the low-to-high transition of the clock pulse, the program counter will be incremented and the Y outputs will be loaded into the memory address register. During the next clock cycle, memory is read and, on the succeeding low-to-high transition of the

clock, the instruction is put into the instruction register of the program sequencer. Only two microcycles are required to complete the instruction fetch.

#### **FILE EXPANSION**

In certain applications, the sixteen registers contained within the IDM2901 are insufficient; thus, the number of registers must be expanded. The expansion is easily implemented via the IDM29903 addressable D register file. As shown in the IDM29903 data sheet, the device consists of sixteen 4-bit words; each word can be read asynchronously or written into on the next clock transition. Figure 8 shows the IDM2901 and the IDM29903 connected together to provide a file that is 32 words deep. As shown by the "file enable" logic and the "expansion interface" connections, it is easy to see how further expansion can be achieved. There are several possibilities which could be used for address decode of this 32-word file. The most versatile decoding system is simply to implement separate addresses for each file, that is, discrete A and B address fields for the IDM2901 and a separate address input for the IDM29903. As shown in the following sequence, extending the number of file registers allows round-robin shifting of information from one device to the other; thus, interfile data management is easily accomplished.

Assume the following file location:

R<sub>0</sub> through R<sub>15</sub> are in IDM2901 R<sub>16</sub> through R<sub>31</sub> are in IDM29903

#### Then:

- 1. R<sub>0-15</sub> + B<sub>0-15</sub> → B<sub>0-15</sub>
- 2. R<sub>0-15</sub> + B<sub>0-15</sub> → B<sub>16-31</sub>
- 3. R<sub>16-31</sub> + B<sub>0-15</sub> → B<sub>0-15</sub>
- 4. R<sub>16-31</sub> + B<sub>0-15</sub> → B<sub>16-31</sub>
- 5. R<sub>16-31</sub> + R<sub>0-15</sub> → Q

In the configuration shown in figure 8, single-cycle shifts do not work, except that  $R_{0.15}$  can be right-shifted or left-shifted. Other shifts can be performed by making a transfer to the Q register, shifting, and then transferring back to the  $R_{15.31}$  registers.

If system requirements prohibit the use of separate address decodes, common address decoding (figure 9) can be used; in this case, two 5-bit address fields are obtained via the IDM29751 and a 2-to-1 multiplexer is used to control the A/B address fields of the 2901.

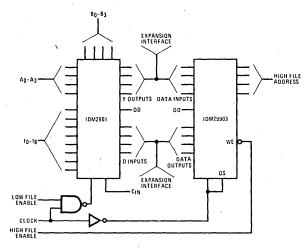


Figure 8. File Expansion Using Separate Address Fields for Each 16-Word File

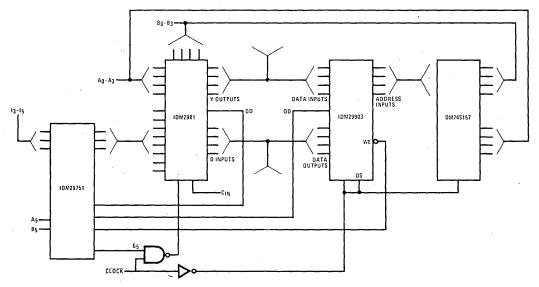


Figure 9. File Expansion Using Common Address Decoding

## USING THE IDM2909A/11A IN A COMPUTER CONTROL UNIT

#### Introduction

In any digital computing system, the Micro Control Unit (MCU) is almost always the most complicated subsystem. The MCU controls and supervises all bus activity, synchronizes internal and external events, and grants or denies access to peripherals and other external systems. Because of these many and varied duties, the MCU is complicated in concept, design, and implementation. The IDM2909A/11A Microprogram Sequencer provides an excellent tool for overall simplification of these parameters.

#### Computer Architecture

Typically, the architecture of most modern-day computers is as shown in figure 10. A common data bus is used; instructions, address operands, data, and other information is sent over this bus under the direction of a microprogram. The series of instructions within each microprogram selects the source of data and also the destination. Although only one data bus is shown in figure 10, a complicated system may contain several busses — each under control of the MCU.

The address bus in figure 10 is used to select a memory word for some internal function, or to select an input/output port for an external subsystem or peripheral. Data sources for the address bus can be the program counter, the memory address register, a direct memory address controller, an interface controller, or other; these functions are also under control of a microprogram command.

The arithmetic/logic unit (ALU) is that part of the processor that does the computational work. With a complex ALU, a large number of arithmetic and logical functions can be performed. As a minimum, the ALU must perform the arithmetic functions "A+B," "A-B," and "B-A"; usually, these functions can be performed in both fixed point and twos complement binary form. The minimum logical functions performed by the ALU are: "A OR B," "A AND B," and "A EXCLUSIVE-OR B." The arithmetic and logical functions are both implemented by the same circuit configurations — the difference being in gating. Besides the arithmetic and

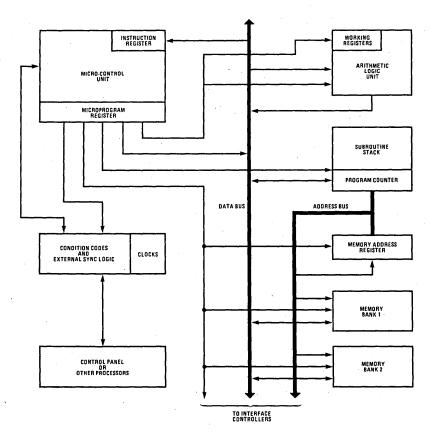


Figure 10. Generalized Computer Architecture

logic capabilities of the ALU, shift and rotate functions are also implemented as part of the basic instruction set. When an arithmetic or logical operation is performed by the ALU, a set of condition codes result. These condition codes include such variables as carry out, A = B, the sign bit, result equals zero, and so on. Along with other status information, these condition codes are stored in a register for later use by the programmer or micro control unit.

Third-generation processors also provide for a general-purpose register set that is available to the programmer to be used to hold variables that are used often — passing arguments to subroutines, referencing memory indirectly, and so on. Depending on the architecture of the machine, the general-purpose registers may be selected directly from the operands in the instruction register, from an address in the microprogram store, or one of the two sources as determined by a bit in the microprogram store.

The program counter and the memory address register are the two main sources of input to the address bus. The program counter contains the address of the next instruction or instruction operand that is to be fetched from main memory, and the memory address register contains instruction address operands that are necessary to fetch the data required for the execution of the current instruction. When exiting a subroutine, a subroutine address stack is provided to allow for easy handling of the return address linkage. The address stack is a last-in/first-out stack that is controlled by a jump-to-subroutine, PUSH, or a return-from-subroutine, POP, instruction from the MCU microprogram word.

In micro- and mini-computer systems, main memory consists of RAMs, ROMs, or more generally a combination of both. Typically, random access memories (RAMs) are slower than the micro control unit and the arithmetic logic unit. On the other hand, read only memories (ROMs) may be much faster than circuits within the MCU. Peripheral devices and multiprocessing systems present the same type of speed-interface problems; also, the MCU must contend with synchronizing events that occur asynchronously.

#### **Control Sequence**

The MCU contains an instruction register, micro-program storage, and usually a microprogram register. The initialization, fetch, and execute phases for a typical micro control unit are shown in figure 11. Regardless of system size and complexity, an initialization sequence is required to put control and storage elements in a known state such that control functions can be implemented in an orderly manner. For example, registers, condition codes, flags, and carry/link flip-flops are preset to a logic 1 or cleared to a logic 0. Likewise, it is sometimes necessary to initialize stack registers and/or main memory. The initialization process must be closely supervised to prevent alteration or damage to peripheral interfaces; furthermore, clock pulses must be withheld from the system until the initialization process is complete.

Usually, the initialization phase (1, figure 11) is started in one of three ways: (1) application of system power, (2) a "master reset" that is programmed or implemented by the operator, and (3) a detected error that cannot be corrected by the program. In a power-up generated initialization sequence, care must be given to the circuits

that detect the event and generate the timed reset signal; the operating sequence should not start until the entire power system is stable. Furthermore, since some equipment and components may be damaged if they require multiple voltages that are not applied in the proper order, the MCU is often used to sequence the enabling of power supplies.

In state 2 of figure 11, an instruction is fetched from the specified memory location and loaded into the instruction register. During state 3, the program counter is incremented and the previously fetch instruction is decoded. If another operand is required for the current instruction, state 3 is repeated and the various operands are loaded into the appropriate register. This process continues until the requirements of the instruction have been met.

In state 4, the macroinstruction is executed. As in all of the other states, the instruction execution state may require one or more microinstruction cycles. After completing state 4, the MCU returns to the fetch phase and continues to fetch-and-execute the programmed microcode.

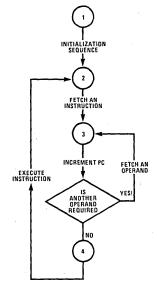


Figure 11. Initialization, Fetch, & Execute Phases for a Typical Microcomputer

#### Architecture of the Micro Control Unit

Basic components of the MCU are functionally shown in figure 12. The instruction register receives the instruction from main memory via the data bus; to minimize system overhead, the registers, main memory, and data bus are all of the same width. An instruction is broken down into two or more fields: the "Op Code" and one or more operands. The Op Code (Operation Code) is the instruction, whereas the operands are data used by the micro control unit in the execution of the instruction. For example, an operand might be the number of a selected register, a variable to be compared to the

accumulator, the address of an input/output port, and so on. Because the operand may be used as data, it must be presented to the data bus via an open-collector or TRI-STATE device; the Op Code and its subfields must also be distributed to the ALU and various other registers.

Usually, a macroinstruction contains more than one microinstruction; also, different classes of macroinstructions almost always require a different number of microprogram steps. In figure 12, some hardware can be eliminated by using the Op Code as the starting address of the microprogram ROM. This technique is not recommended simply because it is wasteful and inflexible; also, the entire system is affected by changes in the instruction set or the microprogram. To avoid these problems, a mapping ROM can be used.

To allow a greater range of starting addresses for the microprogram ROM, the output of the mapping ROM could be wider than the Op Code field that is used as the address input. Because ROM/PROM field widths are typically 4 bits or 8 bits wide, a reasonable choice for an 8-bit Op Code is a mapping ROM that is 12 bits wide. The starting address, as specified by the mapping ROM, is loaded into the microprogrammer counter which points to the first microinstruction in the microprogram ROM. When the output of the microprogram ROM stabilizes, it is loaded into the microprogram register.

The use of the microprogram register in this manner is called pipelining. The pipeline technique improves the overall machine speed by allowing the address of the microprogram ROM to be changed and its output to settle while the current microinstruction is being executed. The microprogram sequence controller in figure 18 performs two basic functions: (1) synchronizes external events, and (2) uses the output of the test condition multiplexer to determine whether or not microprogram branches, jumps to subroutine, and returns from subroutine are to be made.

External signals of the microprogram sequence controller can be grouped into five categories: supervisory, condition codes, initialization, synchronization, and interrupts/clocks. The supervisory signals include "Run," "Halt," and "Pause." "Run" is a latched signal that enables the clock to the entire system. "Halt" disables the system clock and is only recognized during the instruction fetch microcycle; this is a latched signal. "Pause" is a level provided to the controller from an outside processor to temporarily suspend MCU control so that the external processor has uncontested access to resources of the computer.

Condition codes are stored in the program status word register and presented to the test condition multiplexer, where any of the codes may be selected by one of the microprogram fields in the microprogram register. If the condition code is true (logical 1), the output of the test condition multiplexer will enable a branch instruction in the microprogram. The condition codes are loaded into the program status word register after every ALU operation or interrupt request.

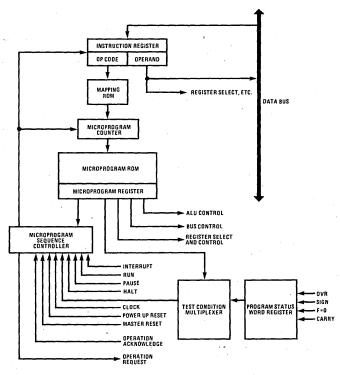


Figure 12. Basic Components of Micro Control Unit

Initialization lines include "Power-Up Reset" and "Master Reset" - these signals have been previously described. Synchronization lines include "Operation Request" and "Operation Acknowledge" - OPREQ and OPACK. These signals are used to synchronize external events whose speed is slower than that of the MCU. For example, when the MCU issues a memory reference instruction, an OPREQ signal is generated and, although the system clock continues to run, it is effectively disconnected from the micro control unit. Once the addressed memory has accessed the data and performed the read or write operation, it generates the OPACK signal; thus, the system clock is enabled to the MCU. When the memory or input/output cycle times are known and can be controlled, the MCU clock period can be adjusted to preclude the requirement for synchronizing signals.

An interrupt may occur at any time; however, it is normally recognized only during an instruction fetch. When the interrupt is recognized, the priority encoded interrupt vector is put into the program status word register and the microprogram ROM is updated with the address of the interrupt service routine. When the interrupt has been serviced, a return to the resident program is made via the previous program counter value.

#### MCU Instructions

There are two types of instructions recognized within the MCU — machine language or macroinstructions, and random logic replacement or microinstructions. Macroinstructions reside in main memory, are fetched and loaded into the instruction register, and then are decoded into microinstructions which directly control

resources of the computer. Two different types of macroinstructions are shown in figure 13. The register-to-register instruction consists of an 8-bit Op Code and two 4-bit operand fields; the branch-on instruction also consists of an 8-bit Op Code but the eight least significant bits define an 8-bit displacement address. In the register-to-register instruction, the operand defines the source and destination registers (A and B), that is, the result of an arithmetic/logic function using registers A and B will be stored in register B. In the branch-on instruction, the condition of the branch is implicit in the Op Code; the sum of the current program counter address and the displacement address will be stored in the program counter if the selected condition is logically true.

The word format for a typical microinstruction is shown in figure 13. The four least significant bits (B<sub>0-3</sub>) define the type of microinstruction (SEQUENCER FUNCTION) that is being executed. The second 4-bit field selects the "BRANCH CONDITION" (if the microinstruction is a branch instruction); two 1-bit fields may enable the interrupt and pause functions if the microinstruction is an instruction fetch command and disables the interrupts at all other times. The third microinstruction field is composed of two 3-bit subfields which are used to define the source and the destination of data (DATA BUS CONTROL). Depending upon the microinstruction function, the remaining 12-bit field is defined either as an arithmetic logic unit control field or as a microprogram branch address field (ALU & BRANCH ADDRESS BITS). There are various methods of mapping microinstruction control fields; however, for implementation of these fields in the examples that follow, the "ALU and Branch Address" is used.

#### Register-to-Register

	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
ĺ			-	Op (	Code		,			Reg	j. B			Reg	j. A	

#### **Branch On Condition**

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
			Op (	Code						D	ispla	ceme	nt		

		,	ALU	& B	ranc	h Ad	dres	Bits	ALU & Branch Address Bits						Data Bus Control				Synchronization Logic								
Fu	uncti	on	s	ourc	е	Des	tinat	ion		tern iatin		S	Sourc	е	Des	tinat	ion	Pause	IEN			nch litior	า			ence ction	
27	26	25	24	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0

Figure 13. Macro- and Micro-Instruction Fields

#### Implementing an MCU Using an IDM2909A

The IDM2909A address controller permits the designer to use the very latest in microprogramming techniques microbranching, microsubroutines, and repetitive microinstruction execution. Instead of using sequential circuits which must be parallel loaded and sequentially incremented with separate clock pulses, the IDM2909A uses a combinational incrementer whose output is transferred to the microprogram counter on the rising edge of the clock pulse. As indicated in the data sheet (Part 1 of this manual), the primary function of the IDM2909A is to present an address to the microprogram ROM such that a microinstruction may be fetched and executed. The address information is available from any of four sources - an Address Register, a Microprogram Counter Register, a Direct or Branch Input, and a Subroutine Stack. The address source (figure 14) is chosen by using the one-of-four address multiplexer select lines, So and S1. The selected address can then be modified by the OR input lines or forced to zero before it is presented at the Y address output lines through a TRI-STATE buffer.

The OR input lines can be used in either of two ways. Selected OR inputs can be set to a logical 1; this will provide the logical OR of the selected address source and the OR input lines at the Y output — in this configuration the address can be "masked." If a microprogram instruction of the SKIP or BRANCH classes is being executed and the microinstruction is aligned on an even address microprogram ROM word (the least significant address bit equals 0), then the least significant OR input

may be controlled by an external test condition multiplexer. If the result of the conditional test is logically false (logical 0), then the least significant bit can be modified to avoid the execution of the BRANCH or SKIP instruction. For such functions, all unused OR inputs must be tied to ground; similarly, if the 2, 3, 4, or n least significant bits of the selected address are 0, the associated OR input lines can be modified for an extended address range skip capability.

It is often desirable to get to a predefined state, or address. For instance, if the machine has just been turned on and it is necessary to perform an initialization sequence or a realtime event occurs where the processor control is required but the ongoing process information may not be destroyed, such as an interrupt, the OR inputs may be used. All of the OR inputs must be connected to the output of a positive logic gate so that when the event occurs the output of the gate goes to a logical 1, as do the Y output address lines. The ZERO input provides a similar capability, but it must normally be held at a logical 1 and only "pulled down" to 0 when the event occurs — causing all of the address output lines to go to 0.

For automatic testing of the memory and register system, the TRI-STATE output buffer that drives the Y lines can be used. That is, if the buffer output control (OE) is disabled, the Y lines are set to the high-impedance state which allows output lines of the automatic tester to be connected directly across the outputs.

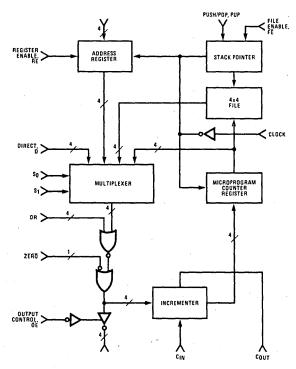


Figure 14. Functional Architecture of IDM2909A

The address register (as well as other storage devices of the IDM2909A) is parallel loaded from the R inputs when the register enable line (RE) is low on a positivegoing clock transition. When entering the starting address of a microprogram, this is the ideal register to use because its contents are not only presented to the Y outputs, but also to the incrementer. The incrementer is an adder provided with an off-chip carry-in signal (Cn) and an off-chip carry-out signal (COUT); accordingly, several IDM2909A devices can be used in a cascade arrangement. The output from the incrementer is connected to a parallel load input on the microprogram counter register where it is loaded on the rising edge of the next clock pulse. If the microprogram counter is selected as the source address by subsequent microinstructions, it will be incremented by each succeeding clock pulse, thereby stepping through the microprogram.

As previously indicated, it is sometimes necessary (and often desirable) to provide a branch instruction and a branch address in a microprogram instruction. In such cases, data lines from the branch address field in the microinstruction can be feedback-connected to the data-direct (D) inputs of the IDM2909A; the source address

multiplexer can then select the branch input as the next microinstruction address. On the next clock pulse, the address is incremented and stored in the microprogram counter register.

The push/pop, or last-in/first-out (LIFO) stack, provides the microprogrammer with the same flexibility in subroutine execution that machine language programmers have. A 4-by-4 file whose address is controlled by a 2-bit up/down counter allows 4-deep nesting of microsubroutines. A push/pop control signal (PUP) determines whether the function being performed is a jump-to-subroutine (PUSH) or a return-from-subroutine (POP). When the file enable control line (FE) is low, the push/pop command is executed on the rising edge of the next clock pulse. After the subroutine is completed, a return to the address immediately following the jump-to-subroutine instruction is accomplished by selecting the stack as the source address and simultaneously executing a POP command.

One method of implementing the hardware shown in figure 12 is a configuration such as that in figure 15. Two IDM29901 octal edge-triggered flip-flops with

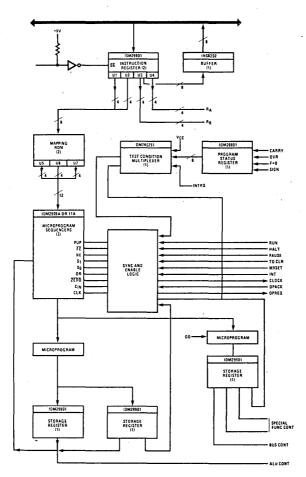


Figure 15. Using the IDM2909A to Implement a Computer Control Unit

TRI-STATE outputs (designated U<sub>1</sub> through U<sub>4</sub>) make up the 16-bit instruction register. The most significant (U<sub>1</sub>/U<sub>2</sub>) registers contain the Op Code, whereas the least significant (U3/U4) registers contain the operand field. The TRI-STATE outputs from the Op Code register are connected to the address input of the mapping ROM. If, as shown, the output enable (OE) is held low by pulling up an inverter, troubleshooting and automatic testing of the system can be simplified because the tester has control of the memory system. The buffered output for the operand field is fed back to the eight least significant bits of the data bus for other register-modification purposes. In some applications, the Operand field for ALU functions will be used as two 4-bit subfields to specify a source register (RA) and a source/destination register (RR). In fact, this arrangement works extremely well if the IDM2901A microprocessor is used. The active TSL outputs are used for RA and RR data.

The two mapping ROMs are connected with common inputs but separate outputs. This memory configuration produces 256 words and a possible unique 16-bit address for each Op Code. There is considerable design flexibility and it is also easy to add additional instructions at a later time. The outputs of the mapping ROMs (or PROMs) connect to the register address inputs of the IDM2909A (or IDM2911A) microsequencers; in turn, the outputs of the sequencers specify address data for the microprogram ROMs. A recommended part type is shown for the region described as the microprogram storage. Since the 2909A or 2911A sequencer solution contains 12 addressing output bits, the size of this storage can grow to 4096 words before the microcontrol design must be modified. Almost any number of PROMs may be used for a system design since the application will dictate the number of words and the width of the word to be used in the microprogram.

As shown in figure 15, the microprogram register is split

one ROM (or PROM) providing special-function
control, bus control, and ALU control, while the left

side provides next state control and the possible next state jump address or ALU control. In this configuration, the starting address from the mapping ROM is loaded into the internal register of the sequencer at some time before it is needed. Alternately, the direct inputs of the sequencer can be used; this method permits a single-cycle branch to the starting address.

The control bit fields for the ALU supervise all external gating and bit manipulation, whereas the other control fields provide source/destination bus control. Whenever the processor is running, the TRI-STATE output enable lines are held low, enabling the output.

If a "Pause" is implemented (a DMA function as an example), the outputs are disabled so that an external or peripheral processor can gain access to the control line.

Depending upon the application, the sync and enable logic can be relatively simple or it can be very complex. On the one hand, these circuits must satisfy the control requirements of the IDM2909A sequencer and the IDM2901, and on the other hand, they must provide the proper interface with externally-generated control signals. For the most part, internal control (within the MCU) is handled by decoding of the functions shown in figure 16.

The ability to execute the same microinstruction a number of times was mentioned earlier; technically, the value of this capability lies outside the micro control unit. For example, consider the macroinstruction format for a register-to-register instruction as shown in figure 19. If the Op Code is a Shift or Rotate instruction, it is desirable for the programmer to move the data word over a range of 1 to 16 bit positions with a single instruction rather than multiple execution of the same instruction. If the two operand subfields (RA and RB) are defined as RA equals the number of bit positions the data is to be moved and RB as the affected register, it is easy to see how this function can be implemented. (Additional hardware requirements are shown in figure 17.)

		Micr	opro	gram	1			N	/licroprog	ram Se	quencer	Contr	ol	
		Se	quen Incti	cer			07	06	05	04	03	02	01	00
-	A4	А3			A <sub>0</sub>	Function Description	TEST ENABLE	OR	ZERO	CIN	RE	FE	SO, PUP	S1
	0	0	0	0	0	Initialize System	L	х	L	Н	Н	н	X	X
	٥	0	0	0	1	Branch Test	Н	L	н	н	Н	н	L	] L
	0	0	0	1	0	Jump to Subroutine Test	Н	L	Н	н	Н	н	L	L
als	0	0	0	1	1	Return from Subroutine	Н	L	Н	Н	Н	Н	L	L
, E	0	0	1	0	0	Execute Program	L	L	Н	Н	н	Н	L	L
B	0	0	1	0	1	External Carry Control	L	L	Н		Н	н	L	L
1 2	0	0	1	1	0		L	L	Н	н	Н	н	L	L
l is	0	0	1	1	1		L	L	Н	Н	Н	н	L	L
Test Condition Disabled or False	0	1	0	0	0		L	L	Н	Н	Н	Н	L	L
i H	0	1	0	0	1	This Group Undefined	L	L	н	н	Н	Н	L	L
Ö	0	1	0	1	0	This Group Origenned	L	L'	Н	н	Н	н	L	L
2 5	0	1	0	1	1		L	L	Н	н	Η :	н	L	L
Ę.	0	1	1	0	0		L	L	Н	Н	Н	Н	L	L
1	0	1	1	0	1		L	L	Н	н	H	н	L	L
	0	1	1	1	0	Load Mapped (Starting) Address	L	L	Н	н	L	н	Н	L
	0	1	1	1	1	Fetch Instruction	Н	L	Н	н	Ĥ	H	L	L
	1	0	0	0	0	This State Undefined	L	_	_	_	_	_		-
	1	0	0	0	1	Execute Branch	Н	L	Н	н	Н	Н	Н	H
	1	0	0	1	0	Execute Jump	Н	L	Н	н (	Н	L	Н	H
Ę	1	0	0	1	1	Execute Return	Н	ᅵᅵ	Н	н	Н	L	L	H
L D	1	0	1	0	0		L	_	_			_	_	
ar	1	0	1	0	1	·	L '	_	-	-	_	-	_	-
) je	1	0	1	1	0		L	-	_	-	_	_	. —	
nat	1 {	0	1	1	1		L	-	_	-	_	-	_	-
Test Condition Enabled and True	1	1	0	0	0		L	_		_	_	_		-
15	1	1	0	0	1	This State Undefined	L	-		] - [	_	-	_	-
puc	1	1	0	1	0		L.	-	_	-	_	-	_	-
ပ္ခ	1	1	0	1	1		L			- 1		_		
Tes	1	1	1	0	0		L	_	_	_	-	_		-
'	1	1	1	0	1		L	-	_	-		-	_	-
	1	1	1	1	0		L	-	_	-	_	-	-	-
	1	1	1	1	1	Service Interrupt or Pause	Н	Н	Н	Н	Н	Н	X	X

<sup>\*</sup>Value of this bit depends on logic implementation.

Figure 16. Function Table for IDM2909 (or IDM2911) Microprogram Sequencer

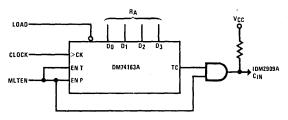


Figure 17. Example of Interactive Microinstruction Control

# SPEED ENHANCEMENT OF BIPOLAR BIT-SLICE MICROPROCESSOR SYSTEMS

#### **Review of Critical Timing Paths**

In order to identify potential areas for speed improvement, it is helpful to review the critical timing paths in a typical bipolar microprocessor. First, consider the simple system organization shown in figure 18. In this system, the address register is clocked at the beginning of the microcycle. When the microinstruction is valid at the ROM output, two basic paths must be considered. One path consists of accessing data from the registers, propagation through the ALU, and storing the result in a data register and a status register. The other path involves the test condition multiplexer and sequence

controller. Typical timing for such a system is shown in figure 19. After the microinstruction is valid, the two paths are indicated by arrows. In a typical system design, the minimum microcycle period is limited by the delay path through the registers and ALU — shown as "ALU Results May Be Clocked" in figure 19.

If the path delays are such that the sequencer output is valid before the path through the registers and ALU has stabilized, a modification to the system shown in figure

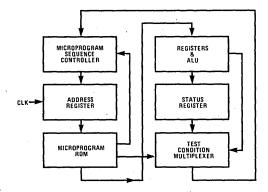


Figure 18. Simplified Block of Microprogrammed Processor

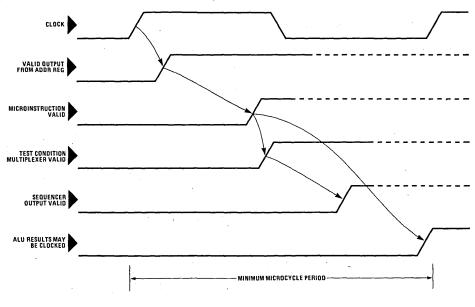


Figure 19. Typical Timing Diagram for Microprogrammed System Shown in figure 18

18 can provide improved performance. Such a modified system with typical timing is shown in figure 20 — this is frequently called a pipelined organization. The name results from the fact that while one microinstruction is being executed, another microinstruction is simultaneously being accessed. A register is added to the output of the ROM and the address register which was used to hold the output of the sequencer logic is not

used. The clock causes the next microinstruction to appear at the output of the microprogram register. The sequencer output is allowed to access the microprogram ROM to fetch the next microinstruction while the data is propagating through the registers and ALU. In this way, the access time of the ROM may be overlapped with the execution of the microinstruction by the registers and ALU.

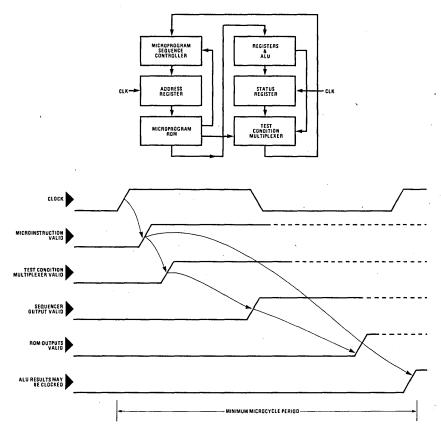


Figure 20. Pipelined Organization with Typical Timing

#### Predicting Test Condition Results for Higher Performance

In order for the pipelined organization of figure 20 to provide a performance advantage over the simple system shown in figure 18, the delay path through the sequencer and microprogram ROM must be faster than the path through the registers and ALU. In the timing diagram of figure 20, the sequencer output is valid early enough for the total access time of the ROM to be overlapped, that is, the ROM access time does not influence the required duration of the microcycle period. To satisfy this condition, the sequencer logic must be relatively high speed, and most importantly, the test condition multiplexer inputs must be valid at an early point in the microcycle. The latter requirement is quite unfortunate, since it implies that test conditions based upon the result of

ALU operations in the current microcycle may not be used. This forces the user to either provide more status register bits (the status register outputs contain the results of operations performed on earlier microcycles) and/or execute an additional microinstruction in order to perform an operation and test the result. Thus the consequences of not permitting test conditions based upon the result of the current ALU operation cost the user both additional hardware and execution time.

An effective solution to this problem is to design the system so that the sequencer logic is conditioned on the basis of a predicted value for the test condition multiplexer output, and the ROM is accessed on this assump-

tion. After the ALU result is stable and has propagated through the test condition multiplexer, the predicted value of the multiplexer output is compared with the actual value of its output. If the predicted value was correct, the next microinstruction in sequence (i.e., the one which was being accessed) is executed. On the other hand, if the predicted value of the test condition multiplexer is different from the actual value, the conditioning of the sequencer logic is modified correspondingly, and the time duration of the microcycle is extended in order to allow time for the modification to propagate through the sequence controller logic and access the ROM. Since the microprogrammer can frequently predict the results of test conditions with a frequency of success that is much better than 50%, a relatively small fraction of the microcycles must be extended. Two examples that illustrate where the programmer can, with a high degree of success, predict results of a test condition are:

- Testing for a stack overflow condition. The stack pointer (contained in an internal register) is compared with a boundary value (contained in another register). It is of course extremely infrequent that the result of this test indicates an overflow condition in normal circumstances.
- Test of a loop counter. In a microprogrammed multiply or divide algorithm, a loop counter must be tested on each pass through the loop. For a 16-bit machine, the test would typically be performed 16 times but the result could be accurately predicted 15/16 of the time.

#### Variable Microcycle Period

As was discussed earlier, the delay through the registers and ALU is typically the path which limits system performance. The magnitude of this delay can vary considerably depending upon which micro-operation is being performed. Table 1 lists a variety of operations together with the microcycle period requirements for a pipelined system which was designed to use the recently announced IDM2901. Note that the longest operation requires about 75% more execution time than the shortest operation (this percentage difference is even greater for a system using the first generation version of the 2901).

Table 1. Microcycle Period Requirements for Various Operations
Using a Pipelined System

Operation Performed	Microcycle Time (ns)
Logic operation; status regis- ter not modified; no test of result	98
Arithmetic operation; status register not modified; no test of result	133
Add and shift; status register not modified; no test of result	172
Multiply cycle; Q <sub>0</sub> used to determine I <sub>1</sub> of 2901	172
Arithmetic operation; status register modified; no test of result	169
Arithmetic operation; status register not modified; result used as test condition (no extend caused by incorrect prediction)	165

The most straightforward design approach is to simply calculate the worst case time period, and design the clock generator circuit to provide that time for all operations. It is evident that a speed improvement would be obtained if the clock generator could be programmed to modify the microcycle period in accordance with the requirements of the operation which is to be performed. If the operations which establish the worst case time period are performed relatively infrequently, then the system performance improvement which can be achieved by programming the microcycle period is greater than might first be imagined.

# Examples of Performance with Various System Configurations

In order to illustrate the performance which results from the various system organizations described above, it is helpful to present numerical values which were obtained from a design study. Five system organizations were considered. The systems were evaluated based upon the time required to execute a variety of instructions typical of those used by a minicomputer. These results are useful for gaining an insight into the performance which may be obtained for a particular type of system organization. Obviously, the results of these studies are dependent upon component specifications - ROMs, registers, gates, and LSI devices. Thus, when choosing an organization for a new system design, the designer should perform a similar analysis using specifications of available components in order to make realistic decisions of cost versus performance.

System 1: This system was equivalent to that shown in figure 18. It was a non-pipelined organization and test conditions were based upon results of operations performed on the previous microcycle. A fixed microcycle period of 225 nanoseconds was used; this period was necessitated by the multiply instruction.

System 2: This evaluation was based on a "pipelined" system organization similar to that shown in figure 20. Test conditions were based upon results of previous microcycles and a fixed microcycle time of 172 nanoseconds was used. The pipelined organization allows the microcycle period to be reduced by 48 nanoseconds less than the cycle time for System 1.

System 3: This system was the same as System 2 except that test conditions based upon results of the current microcycle were used and the technique of predicting test condition results was utilized. The microcycle period was fixed at 172 nanoseconds. The time necessary for the result of the current operation to propagate through the test condition multiplexer and determine whether an extended cycle was needed did not require a longer period than the 172 nanoseconds established by the operation needed by the multiply instruction. An extended cycle adds 86 nanoseconds (one half microcycle) to the normal microcycle period.

System 4: This system was the same as System 2 except that a variable microcycle period was used. Test conditions were based upon the results from the current microcycle; however, no prediction of test conditions with an extended cycle for incorrect prediction was performed. Instead, those microinstructions which required more time to allow for propagation of the result through the test condition multiplexer and sequence controller were simply programmed to be of

longer duration. Microcycle periods of either 103, 137, 172, or 206 nanoseconds could be used depending upon the needs of each microinstruction. A conditional branch based upon the result of an arithmetic operation requires 235 nanoseconds with this system organization. This time exceeds the period of the longest available microcycle (206 nanoseconds). However, the conditional branch may be executed with adequate time margin by repeating the arithmetic operation on two successive microcycles: one of 130 nanoseconds followed by one of 137 nanoseconds - a total of 240 nanoseconds. Although this approach of repeating the arithmetic operation may require more microcode locations, it does offer even greater flexibility in tailoring the microcycle period to the needs of the operation being performed.

System 5: This system combines the techniques used in Systems 3 and 4. Variable length microcycles (103, 137, 172, or 206 nanoseconds) could be used. The technique of predicting test condition results was used and, when the cycle was extended due to an incorrect prediction, an additional 86 nanoseconds were added.

Table 2 shows the instructions typically used in a minicomputer that is configured in one of the foregoing system organizations. The execution times specified in table 2 for each instruction type were derived by using the execution time of System 1 as a baseline reference. The relative execution speed for each of the five systems can best be appreciated by examining the data given in table 3. The instructions (described below) were chosen for a variety of reasons:

- LD, JMP, and ST (Load, Jump, and Store) were chosen because they are among the most frequently used instructions, and thus are ones for which execution time optimization is quite important. Since these instructions do not involve test conditions based upon results of ALU operations, note that the technique of prediction does not improve the execution time.
- 2. JSR and BOC (Jump to Subroutine and Branch on Condition) are frequently used instructions. They were chosen in order to illustrate the advantages of prediction of test condition results. For JSR, it was assumed that the test condition result was always predicted correctly (i.e., no stack out of bounds occurs). For BOC, it was assumed that the test condition result was predicted correctly 50% of the time. The two values given for BOC correspond to the cases where: (a) there is no branch and (b) the branch occurs.
- 3. ADD and MOVE were chosen primarily because they are used by some as a figure-of-merit for machine performance. The figure shown for MOVE is the time needed for each pass through the loop which reads data from one location in memory and stores it in a second location. The advantage of the technique of prediction of current test conditions from previous microcycles does not show up in the figures shown by JSR and MOVE. This is because it was possible to

Table 2. Instruction Execution Time (ns) with Various System Organizations

	l .	Ir	struction Ty	pe	
System Organization	LD, JMP, & ST	JSR	вос	ADD	Loop for MOVE
System 1 — non-pipelined; test condition from previous µcycle	920	1610	920 or 1150	920	920N
System 2 - pipelined; no prediction; test condition from previous µcycle	688	1204	688 or 860	688	688N
System 3 — pipelined with prediction; test condition from current $\mu$ cycle	688	1204	559 or 731	688	688N
System 4 — pipelined; no prediction; variable length $\mu$ cycle; test condition from current $\mu$ cycle	480	960	482 or 619	549	617
System 5 - pipelined with prediction and variable µcycle length	480	892	412 or 549	549	549N

Note: The reason JSR & Loop for MOVE don't improve with System 3 is that a way was found to write a code without an extra cycle.

Table 3. Relative Instruction Execution Rate with Various System Organizations (Execution speed as a speed improvement factor of System I)

		It	struction Ty	pe	
System Organization	LD, JMP, & ST	JSR	вос	ADD	Loop for MOVE
System 1 — non-pipelined; test condition from previous µcycle	1.0	1.0	1.0 or 1.0	1.0	1.0
System 2 – pipelined; no prediction; test condition from previous µcycle	1.34	1.34	1.34 or 1.34	1.34	1.34
System 3 — pipelined with prediction; test condition from current $\mu$ cycle	1.34	1.34	1.64 or 1.57	1.34	1.34
System 4 — pipelined; no prediction; variable length $\mu$ cycle; test condition from current $\mu$ cycle	1.91	1.67	1.91 or 1.85	1.67	1.49
System 5 — pipelined with prediction and variable μcycle length	1.91	1.80	2.23 or 2.09	1.67	1.67

write the microprogram with the same number of microinstructions for both systems. This was not the case with BOC, where an additional microinstruction was needed in order to conform to the requirement that test conditions be based upon results of the previous microcycle with System 1 and System 2.

#### Conclusions

Execution time calculations were made for a system where the macro-level instructions and data are stored in a (main) memory with very fast access time. Thus, it is assumed that it is not necessary to extend the clock cycle when reading from main memory. Although this is frequently not a valid assumption, it was necessary in order to simplify the presentation of results. If the memory access time is significant (say, greater than 200 nanoseconds), the relative improvement which can be obtained with the system organizations described here is somewhat less impressive. This is because the main memory access time may be overlapped to a greater extent with the system organizations having longer microcycle times. The overlapping is particularly important for those instructions which make multiple memory references, that is, LD and ST instructions require two memory reads, whereas the JMP instruction requires only one memory read. Conclusions may be drawn based upon a study of the results presented in table 3. Observe that the technique of using a variable microcycle period provides an impressive improvement in performance. Of course, this is a direct result of the fairly wide range of time intervals required for the various micro-operations presented in table 1. When the micro-operations which are performed most frequently can use the short execution cycle, the performance gained from the variable microcycle period has the most impact on overall throughput of the machine. When designing a machine with variable microcycle periods, the clever designer will concentrate his efforts toward speed optimization for the most frequently performed micro-operations. It may be possible to save hardware costs by allowing the microcycle time required for the infrequently performed operations to be longer. Thus, the variable-length microcycle approach to design offers design freedom which can possibly reduce costs as well as improve performance.

#### Timing Generator Design Example

A timing generator which has been designed to meet the general objectives discussed in the preceding paragraphs is shown in figure 21. This circuit generates one of two clock intervals (oscillator period x 4 or x 6) under microprogram control. A variation of this basic idea but providing a choice of four clock periods (4, 5, 6, or 7 times the basic oscillator period) is shown in figure 22. The circuit also provides for comparing the output of the test condition multiplexer with a predicted value (from the microprogram ROM). If the actual test multiplexer output does not match the predicted value, the clock period is extended (by 3 oscillator periods) and an alternate set of inputs to the sequencer logic is provided.

The key element of the circuit is a 74S195 shift register. Use of Schottky circuits allows operation at an oscillator frequency up to 33 MHz. This permits the generation of a microcycle period of 120 ns with programmable increments of 30 ns (for the clock generator which provides four programmable clock intervals, this would allow clock periods of 120, 150, 180, and 210 nanoseconds).

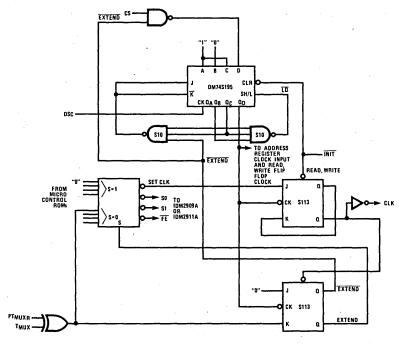


Figure 21. Two-Interval Programmable Timing Generator

Figure 22. Four-Interval Programmable Timing Generator

The operation of the timing generator is best understood by reference to the state diagram shown in figure 23. Transitions from one state to another are made on each rising edge of OSC. The state of the shift register (QAQBQCQD) along with the state of CLK (the system clock) is specified in the state diagram. Assume that the clock (CLK) has just made a 0-to-1 transition indicating the start of a new microcycle (1110, CLK=1). EXTEND is a logic 0. The new outputs of the microprogram register then become valid resulting in the new values for Cycle Select (CS). (CS is a 1-bit value for the 2-interval circuit and a 2-bit value for the 4-interval circuit.) Cycle Select (CS) determines the state transition after CLK has been high for almost two OSC periods and thereby programs the duration of CLK. This is achieved by parallel loading the shift register with the desired value. State transitions then occur as determined by shifting the DM74S195. The clock input to the flip-flop which generates CLK is provided by the QD output of the DM74S195. CLK goes low when the DM74S195

reaches the 1010 state. On the next negative-going transition of QD, after CLK has been low for almost two OSC periods, the SETCLK output of the DM74S158 2:1 multiplexer determines whether CLK is set (the case when TMUX, the output of the test condition multiplexer is the same as PTMUX, the predicted value of TMUX) or CLK remains reset (corresponding to the case where TMUX is different from PTMUX). If CLK is set at this time, the sequence which was described above repeats in the same fashion. On the other hand, if TMUX was not predicted correctly, CLK will remain reset, and EXTEND will go to a logic 1. This causes the DM74S158 multiplexer to select the alternate set of inputs to the micro-sequencer logic (So, S1, and FE) and causes SET CLK to go to a logic 1. After EXTEND has been active for three OSC periods (thus providing time to allow for propagation through the sequencer logic and microprogram ROM access), QD will make another negative-going transition, and CLK will be set, which in turn causes EXTEND to return to its logic 0 condition.

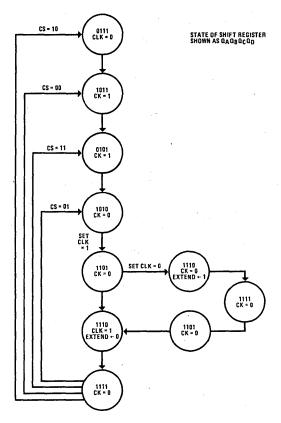


Figure 23. State Diagram for Four-Interval Programmable Timing Generator

## Bit-Slice Microprocessor Design Takes a Giant Step Forward with "Schottky-Coupled-Logic" Circuits

National Semiconductor Application Note 203 July 1978



A new four-bit slice "Schottky-coupled-logic" design combines the flexibility of the industry standard 2900 microprocessor architecture with advanced LSI processing. It implements low-power Schottky TTL circuitry on the same devices as a proprietary TRI-STATE™\* emitter coupled logic design to achieve a 30 to 50 percent improvement in speed with no increase in power dissipation. It also allows the use of advanced "pipeline prediction" techniques in microprogram control design to significantly reduce microcycle times.

In most computer applications, cost, speed, power consumption and utility are the key factors. In some applications cost is the dominant consideration. In others it is speed or power consumption.

In bipolar four-bit slice microprocessor-based systems, this is particularly true. To date, however, designers have had to make a choice between the high speed of emitter coupled logic or the low power consumption and low cost of low power Schottky TTL four-bit designs such as the industry standard 2900 series.

But with current approaches it has not been very practical to have both.

If the designer chose an ECL design, he paid a price for the high speed with higher power consumption and loss of board design flexibility. If one of the LS bipolar 2900 designs currently available was chosen, low power could be achieved, but only at the price of considerably reduced system throughput.

Now, however, computer system designers can have both ECL-type speeds and LS bipolar power consumption. Using a new advanced "Schottky-coupled logic" technique that combines low power Schottky circuitry on the same die as proprietary low power TRI-STATE ECL circuitry, the IDM2900 series of four-bit slice microprocessor components has been developed by National Semiconductor Corporation.

With this patented "SCL" technique, devices have been fabricated which are 30 to 50 percent faster than comparable 2900 designs now available. At the same time power consumption is slightly less than that for present LS bipolar designs and one third of that required for ECL-based designs.

The substantially increased system throughput made possible by this new series of SCL implemented IDM2900 parts means a number of advanced computer designs can be considered which were not possible before. For example, advanced "pipeline prediction" techniques in microprogram control design can be used to significantly reduce microcycle times.

An interesting byproduct of this approach is that this is the first ECL-based four-bit slice family to meet the military requirements over the military temperature range. Indeed, the new series shows even less performance degradation over the military temperature range than some of the standard LS bipolar parts now available.

#### A 60 Nanosecond Slice

The process and circuit improvement that have been achieved are the most apparent in the IDM2901, which boasts an average microcycle time of only 60 to 70 nanoseconds, a 100% improvement over existing LS bipolar designs. Power consumption, however, is about the same, only 800 milliwatts for the entire device. Also available is an even faster version — the IDM2901A-1 — with a microcycle time of only 50 to 60 ns, and no increase in power consumption.

As with other implementations of the 2900 architecture, the IDM2901 is the key element in this high speed family of four-bit slice components. Designed as a high speed cascadable element intended for use in CPUs, peripheral controllers, programmable microprocessors and numerous other applications, the IDM2901 consists of a 16-word by 4-bit two-port random access memory, a high speed arithmetic logic unit and the associated shifting, decoding, and multiplexing circuitry. (See figure 1.)

Indeed, except for that most important parameter speed — the IDM2901 is plug compatible with any LS bipolar implementation of the same architecture now on the market. But plug in replacement and raw speed improvements are just part of the story. As can be seen from tables 1 and 2, the IDM2901, for example, has improved significantly almost every timing parameter possible. The read/modify/write cycle is 42 percent less, the maximum clock frequency 68 percent greater. Execution time for a typical operation, such as an add and shift (multiply) is 95ns maximum and 60ns typical, a significant gain over previous 2900 implementations. (See table 3.) Used in a typical design, system microcycle time is in the 100 to 150ns range, about one half to two thirds that of previous LS bit slice implementations.

These circuit and process improvements have been implemented in many of the standard components needed to build a system based on the 2900 bit slice architecture. In addition to the IDM2901 , nine other standard parts have already been introduced. These will allow system designers to take advantage of the increased speed.

\*A trademark of National Semiconductor Corporation.

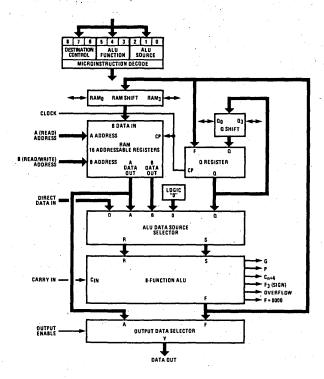


Figure 1. Block Diagram

Using some of the standard parts in the IDM2900 family, a typical 16-bit controller function can be implemented with a system microcycle time of about 140ns. This represents about a 30 percent improvement over that achieved with LS bipolar devices. Using the high speed IDM2901A-1, system throughput can be reduced to about 120ns. Using the proprietary parts added to the family, the same functions can be done in even less time, about 120 and 100ns, respectively.

Figure 2 shows a very simple, very fast state sequencing controller designed using IDM2900 family parts. It has no arithmetic capability, but 80ns clock intervals can be used. A less complex controller is shown in figure 3. It utilizes the IDM2901 for its data storage and arithmetic or logic generation. The IDM2911A is used as the state sequencer for this controller since its speed and subroutine stack can be used to advantage in the application.

#### LS + ECL = SCL

To achieve this combination of ECL speeds and LS bipolar power consumption, several techniques are used. One is to use low power Schottky circuitry in the periphery of the chip for input/output and interfacing to external TTL levels and the ECL internally — a technique commonly used in some bipolar memories. (See figure 4.)

Traditionally, ECL to TTL translators are slow unless considerable power is applied. In the IDM2900 family, however, the ECL speeds are retained, but at no cost in additional power, thanks to a TRI-STATE translator circuit technique that transforms the 0.7 volt ECL levels to 5 volt Schottky levels. This technique eliminates the slow and power consuming buffer transistors that usually do the job, and the translators can drop off to one third their active power with no loss in speed. Using this TRI-STATE translator technique, the extra 60 to 65 percent in power that would have been consumed is pumped instead into the portions of the device that require it; specifically, the ECL core circuitry.

Table 1. Percentage Improvement in Cycle Time and Clock Characteristics

Time	IDM2901A
Read-Modify-Write Cycle	40% less
Maximum Clock Frequency	6%
Minimum Clock Low Time	same
Minimum Clock High Time	same
Minimum Clock Period	40% less

Table 2.

Percentage Improvement
In Maximum Combinational Propagation Delays for IDM2901A and IDM2901A-1\*

to Output							Shift O	utput
from Input	Y	F <sub>3</sub>	C <sub>n + 4</sub>	Ğ/P	F = 0 R <sub>L</sub> = 470	OVR	RAM <sub>0</sub> RAM <sub>3</sub>	O <sub>0</sub> O <sub>3</sub>
A, B	19 (38)	19 (38)	13 (33)	8 (31)	22 (50)	24 (30)	26 (42)	
D (arith mode)	11 (29)	11 (29)	11 (29)	0 (14)	8 (47)	18 (27)	23 (46)	
D (1 = x37)	0 (20)	0 (20)			0 (42)		17 (36)	
C <sub>n</sub>	0 (17)	0 (27)	0 (20)		20 (40)	0 (17)	30 (30)	
I <sub>2,1,0</sub>	0 (27)	9 (55)	0 (30)	0 (33)	14 (43)	23 (62)	20 (40)	
I <sub>5,4,3</sub>	9 (30)	9 (30)	9 (30)	10 (36)	21 (43)	23 (31)	33 (40)	
18,7,6	0 (17)				,		0 (0)	0 (0)
OE Enable/Disable	14/0 (43/20)							
A Bypassing ALU (I = 2xx)	11 (11)							
Clock	0 (17)	0.(25)	0 (25)	0 (20)	20 (33)	27 (27)	25 (31)	0 (0)

<sup>\*2901</sup>A-1 in parentheses.

The output translators use both linear and digital techniques. Differential ECL signals are translated using a differential current amplifier where the differential output voltage is changed to a differential current and then back to an output voltage. This drives a phase splitting transistor used to, in turn, drive the output circuitry in the periphery. Key to the operation of these translators is the use of an improved TRI-STATE logic buffer circuit characterized by a current mirror transistor having its base and emitter, respectively, connected to the base and emitter of the phase splitter transistor, and its collector connected to the voltage supply terminal. (See figure 5.) The emitter size on the current mirror transistor is about twice that of the emitter size of the phase splitter transistor.

The current mirror transistor supplements the drive current that is provided by the phase splitter transistor to the pull-down output transistor. This permits a higher resistance to be connected between the voltage supply terminal and the collector of the phase splitte transistor without diminishing the drive current to the pull-down output transistor. By connecting a higher resistance, the power for the circuit is reduced when the output is in its disabled state.

An additional advantage realized as a result of the current mirror transistor base and emitter connected, respectively, to the base and emitter of the phase splitter, and its collector to the supply voltage terminal, is a faster dynamic response in the conduction state of the pull-down output transistor to a change in the level of the digital data input signal. This occurs due to the selective use of the Miller feedback effect to cause a beneficial ratio change in the current mirror pair during a dynamic transition. Miller feedback occurs on the phase

splitter transistor because its collector is coupled to the voltage supply through a resistance, and is absent on the current mirror transistor because its collector is directly connected to the voltage supply terminal. As a result, with the onset of the transition in the digital data input signal, as received from the collector of the input transistor, the current ratio between the current mirror and phase splitter transistors is even greater than the ratio of the respective emitter sizes.

Internally, the ECL logic has level translators on each input. This necessary circuitry achieves not only the level translation, but also has a very desirable input level sensitivity. As can be seen in figure 6, the translator is similar to a differential amplifier whose internal reference is stable. The result is very abrupt transfer characteristics on all input signals, and, thus, very fast switching speeds.

#### Improved Computer Design

The substantially increased system throughput made possible by this new series of SCL-implemented IDM2900 components means a number of improved bit slice processor designs can be considered which were not possible before.

Compared to simple control applications, there are a number of other factors to be considered when using IDM2900 series devices in more complex processor systems. The general changes which take place relate to special handling of data and address outputs and data inputs. The IDM2901 's register and ALU elements are no longer sufficient, especially when data and address word lengths grow from 8 to 16 bits or greater. Special functional elements are generally added, and include: input and output data or addressing registers, sign extend of

Table 3.

Maximum Throughput Comparisons for Add and Shift

Function	IDM 2901A-1	IDM 2901A	AMD 2901A	AMD 2901
A or B $\rightarrow \overline{G}$ or $\overline{P}$	45	60	65	80
74S182 Delay	10.5	10.5	10.5	10.5
CIN → RAM <sub>0</sub>	35	35	50	55
RAM Setup Time	15	20	25	55
Total	105.5	125.5	150.5	175.5
Percent Change	40%	28%	14%	0%

data, and instruction decode, as well as shift and rotate control, and multiply functions. Also, special processor status registers are quite often added, as well as the unique controls for these elements.

Some special thought applied to these areas can reduce the parts count considerably and improve processor performance when using IDM2900 components.

The sign extend function is a good example of what can be done. Sign extension of a data word can be accomplished in a number of ways. But what the designer of the processor would prefer is to implement the function with the fewest possible parts and at the fastest data inputs. The first solution that comes to mind is the use of multiplexers, as shown in figure 7, which allows data to be fed through the multiplexer to D inputs of the IDM2901's. The control function which steers the data to the D input representing the bit which needs to be extended normally comes from the microprogram store. The added delay using this path is 12ns or more if parts slower than the DM74S157 are used. For each 4 bits of data to be modified an additional component is required; 2 parts for 8 bits, 3 parts for 12 bits and 4 parts for 16 bits.

The IDM2900 family, however, allows consideration of a number of other ways to do sign extension that require fewer parts and are less expensive and faster.

One is to use the carry input to accomplish a sign extend. But to use this input one must subtract "1" from "0" conditionally if the sign bit is a "1" and the opposite if it is a "0." But the problem arises as to how to obtain a value "0" in a register, an impossibility.

But the same effect can be achieved if the same address location is placed upon both the A and B address inputs. The source code is then used to select A and B and the function code for subtract. Now, if a carry input is a "1" the result is a "0" and if the carry input is a "0" the result is an all "1s" sign extend result. This technique can propagate for as many packages as necessary since the carry logic is necessary for other functions and is already included.

An easy method of inserting the conditional carry with the IDM2901 is to use the IDM2902 in a manner that is different from standard LS bipolar designs. Instead of connecting the carry input of the 2902 to the microcontrol carry from ROM, it is connected to the carry out of the least significant IDM2901 package. Note that this is just as fast as the previously suggested connections since the G and P are only slightly faster than the carry out of the least significant IDM2901. Doing this allows one free G and P input to be available at the second level, as indicated in figure 8.

It is only necessary to connect an AND gate to the input and sign extend is accomplished. The lower bits which want to be entered without modification need only be applied to the D inputs and a source code selected to perform a D minus 0 transferred to B. The most significant package group produces A minus B where A and B are as described before. An all-1s or all-0s result is obtained dependent upon the value of the data bit to be extended. The result is a sign extension with three fourths of a package for any sign extend, achieved at no loss in normal cycle time. This is because a carry input change can occur later in a cycle than a change of D.

#### Performing a Multiply

Most of the time the name of the game in computer processor design is speed. Nowhere is this more true than when it is necessary to perform a multiply. This is because the multiply determines the longest cycle time if performed in the normal manner. This is because more than one path through the 2901 is utilized. Passage through several external components is usually required and this must also be added to the solution time. However, with the use of high speed components in the IDM2900 family it is possible to circumvent and shorten this path, and thus shorten the multiply cycle time.

How this is done is clearly understood only by referring to a specific example. Let's assume the problem is to perform a multiply of two signed 16-bit values.

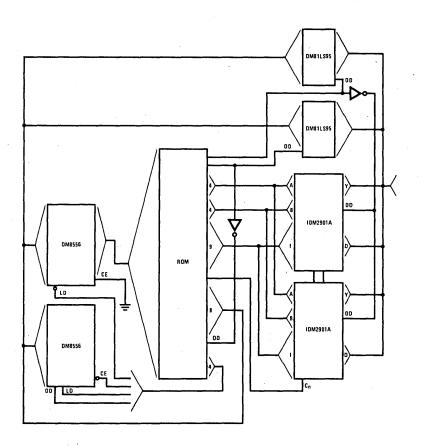


Figure 3. Small High Speed 8-Bit Controller with One Level of Subroutine Capability.
This solution can run at 100ns cycles.

Figure 8 is the circuit as implemented using IDM2900 devices with the two multiplexers (74S253) and a D flip-flop (74S74). Using IDM2900 components and this technique, the multiply is performed 30 to 70 nanoseconds faster per cycle than with standard LS bipolar bit slice parts. This is a total speed improvement of 480 to 1,120ns.

An additional significance to the design is that special multiply cycle time intervals are not required. This operation, therefore, makes possible a processor or controller with a less complicated clock control circuit.

Note that in figure 8 there is an extra stage of register storage in the Q register (D type flip-flop), compared to traditional designs. It is therefore necessary to shift Q one time without shifting the file register.

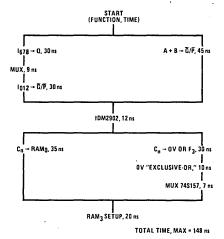
Since it is necessary to clear the partial product register, the Q register is shifted the first time so as to get the least significant bit into the extra storage location.

After this, the A and B register file addresses do not change and therefore do not enter into the timing equations. The much faster response time of an added D flip-flop saves a great deal of time in each microcycle of the multiply add and shift operation.

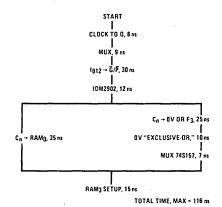
Since the A and B inputs do not change the critical path is from the D register output into the  $l_{O12}$  inputs and through the IDM2901As in a normal add and shift operation. Using the Q flip-flop, 20ns is saved, and using the  $l_{O12}$  input, 10ns is saved in each of the 16 cycles of the 16-by-16 multiply. This is all that is necessary for a positive signed multiplicand. But if a negative result is required, an additional path must be added.

The two possible paths in the most significant IDM2901A package are from  $C_n$  to RAM0 output or from  $C_n$  to Overflow or  $F_3$  and through the additional exclusive-OR gate and multiplexer input to the RAM3 input. The maximum time delay path is 20ns from overflow and  $F_3$  outputs back to the RAM3 input for the most significant 2901A package.

Using standard techniques common to previous 2900 designs, only 15 conditional adds, followed by a shift and one conditional subtract and then a shift, are required to do a signed multiply in 2s complement notation. The resultant data paths required for this solution are as follows:



But if the circuit described in figure 8 is used, and the A and B address lines are set up one cycle ahead of the multiply sequence, the following timing comparison, using IDM2901A-1s instead of IDM2901As, prevails:



A net savings of 32ns per microcycle is thus achieved with this change. It can now be seen that sometimes it pays to add a flip-flop in certain locations to achieve higher performance so as to achieve a simpler solution in other areas. Here, a 20

#### Improving Microcycle Times with Pipeline Prediction

percent reduction in cycle time was achieved.

Perhaps the most important aspect of National's IDM2900 family of high speed, low power SCL components is the impact on how microprogram state sequencing is implemented in bit slice designs. The ultimate result will be further improvements in microcycle times beyond anything now possible with present 2900 bit slice families.

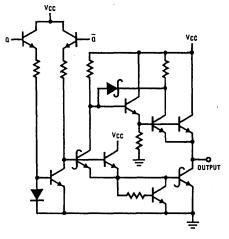


Figure 4.

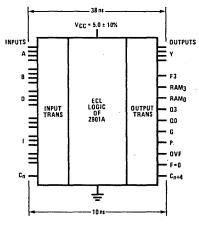


Figure 5.

In the very earliest use of state sequencing — in minicomputers and larger systems — operations were performed in series, one after the other, and the microcycle was defined as the sum of the operations. (See figure 9.) Still in use in some designs today, in this approach a state sequencer increments to the next state or branches to a next state depending on the logic level of the test input. In this solution the controller timing is from the clock edge of the controller register/counter through microcontrol storage (ROM) and the processing elements (2901s), then back through the next state decision tree to the controller-register counter.

The second approach is called "pipeline microcoding," and is an approach commonly used in bit slice systems such as the standard LS bipolar 2900 family. (See figure 10.) In this solution the microcontroller loop timing is operating in parallel with the execution of the processing component section.

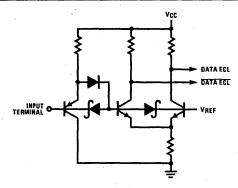


Figure 6.

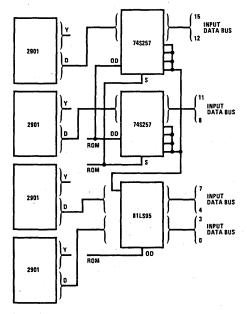


Figure 7. Sign Extend Using Multiplexers

During the time an arithmetic operation is being performed, the next microcontrol word is being set up for use by the microcode. The microcode for the present register/ALU operation occurs during the previous operation. The use of the register between the output of the microcontrol store and the 2901s allows the two sections to function with overlapped timing. The result of this type of micro-sequence control is a faster machine cycle time than used in the totally serial mode of operation.

Also required in this mode of operation is the absolute knowledge of the next state control one cycle before the execution of the 2901 cycle. It is therefore difficult to implement a number of successive conditional next state decisions. This type of microcontroller is said to be operating in a "pipeline" mode in that the next state microcontrol is being obtained during the time the previous one is being executed.

Using SCL-implemented IDM2900 components instead of LS bipolar bit slice devices in this approach results in a 65 to 75 percent reduction in the register/ALU portion of the microcycle. In spite of this, total microcycle time may be reduced only 40 to 50 percent. This is because the microcycle time is determined by the length of the longest operation, which in this case can be the delay in the microcode portion.

To get the full benefit of the high speeds inherent in National's SCL family therefore means abandoning the traditional approach to pipelining used in previous 2900 bit slice designs. What can be used instead is a different technique — pipeline prediction — which allows a reduction in the microcode portion of the microcycle so that it is equal to or less than the register/ALU setup time. The relative timing comparisons between these four approaches are shown in figures 11A through 11D.

The "pipeline prediction" controller functions in much the same way as the standard pipeline configuration except that it can also accept any number of successive conditional next state decisions in a row. microcontroller "pipelines" This microcontrol sequences in much the same manner as the previous design and for the same reasons. But shorter microcycles can be obtained due to the fact that during any microcycle the most predictable next cycle is being set up. But should the test of the next state decision be different from the one predicted, then the alternate state is conditioned and the microcontroller and the data system pass through a correction interval.

This design makes next state decisions within the same cycle as microcontrol of the IDM2901. Figure 12 shows a "pipeline prediction" technique where the next state is a choice between two states. This means one state is predicted, and if incorrect the second choice is used. The microcycle is either delayed or an additional cycle is inserted.

There is no real reason why the design must be limited only to two next state conditions. Any number may exist. It is only necessary to predict the most probable next state and correct it if necessary. Most next state decisions are known to a high probability of occurrence. The additional cycle time added for the few times an incorrect prediction is made is extremely small compared to the total microcycle time saved. Additional speed is obtained with this technique since it minimizes the number of states through a control sequence.

Finally, pipeline prediction requires no increase in the number of components to achieve these increases.

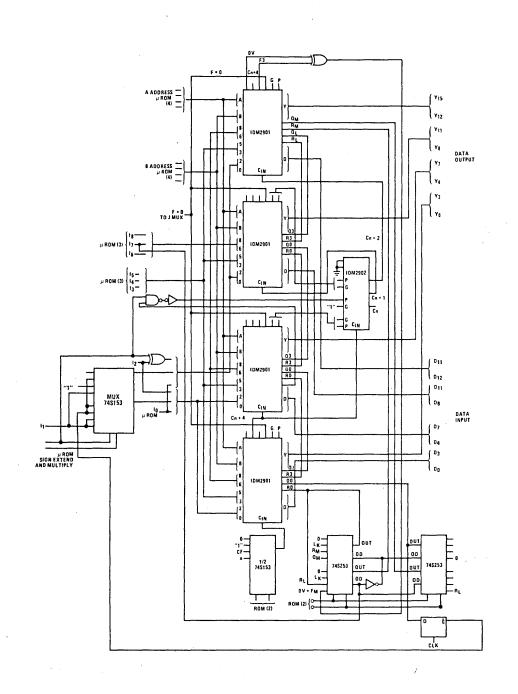


Figure 8. 16-Bit Register/ALU Design

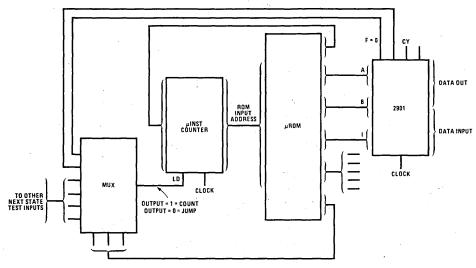


Figure 9. The Simple Microcontroller

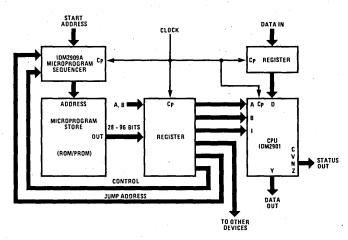


Figure 10. Microprogrammed Architecture Around IDM2901s

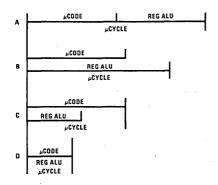


Figure 11. History of the Microcycle

#### **Future Trends**

By using higher speed parts such as the IDM2901A-1, greater improvements in throughput are possible.

And in the future there is the possibility of even further improvements, particularly on the chip processing level. The present components in

National's IDM2900 SCL family have been designed with exceedingly liberal design rules. In spite of that, the chip area on the IDM2901 , for example, is equal to or less than that of some of its LS bipolar counterparts.

What this means is that there is inherent in the SCL technique the possibility of further improvements in density and integration — combining of many bit slice functions onto fewer and fewer chips — while maintaining speed.

It's not unreasonable to expect speeds on SCL-type bit slice 2901A parts to be in the 40 to 50ns range by the end of the decade and system throughput figures to be in the 80 to 90ns range. Even though SCL microcycle times at the component level may not match pure ECL-implemented parts, the system improvements allowed by the lower power may ultimately result in the design of systems with throughputs far in excess of what is possible with emitter coupled logic — at much lower power and cost.

Figure 12. Microsequencer Controller for Pipeline Prediction

National Semiconductor Application Note 217 May 1979



#### High-Speed Bit Slice Microsequencing Design

With the advent of higher speed versions of the industry standard 2900 bit slice microprocessor family, numerous options are now available to the system designer.

Using traditional approaches to bit slice system design, even the simple replacement of low speed, low power Schottky devices with a higher speed part, such as the IDM2901A-1, means an improvement in system throughput of 30% to 50% (Tables 1A and 1B). More importantly, these high speed parts mean a number of advanced computer designs can be considered, resulting in greater flexibility in making design tradeoffs between speed and parts count.

Table 1a. Maximum Cycle Time to STATUS Outputs\*

Function	IDM2901A-1	IDM2901A
2901A A or B to G or P	45 ns	60 ns
74S182 $\overline{G}$ or $\overline{P}$ to Carry Out	7 ns	7ns
2901A C <sub>in</sub> to F0, F3, C4 or OVR	30 ns	40 ns
Total	82 ns	107 ns

<sup>\*</sup>Add applicable pipeline register timing.

Table 1b. Maximum Dedicated Signed Multiple Cycle (Conditional Signed Add and Shift)

Function	IDM2901A-1	IDM2901A
74S74 Clock to Out*	9ns	9ns
2901A I1 to G or P	30 ns	45 ns
74S182 ₲ or ₱ to C Out	7ns	7 ns
2901A Cin to F3 or OVR	25 ns	30 ns
74S86 Propagation Delay	10.5 ns	10.5 ns
2901A RAM Setup	-15 ns	20 ns
Total	96.5 ns	121.5 ns

<sup>\*</sup>Use a 74S74 as Q0 output, then connect inverted 74S74 output to I1 to realize a 19 ns saving.

To take advantage of these high speed parts, an equally fast microcontrol loop is required, so that this portion of the system is a help and not a hindrance in increasing total throughput.

A number of microcontroller loop circuit configurations have been developed to take full advantage of these high speed parts. The choices are by no means exhaustive. Their purpose is to serve as an example for the designer; a starting point from which new designs can be developed.

#### MICROCONTROL AND THE MICROCYCLE

The object of the microcontrol portion of a processor or controller is to access the next control word to be used by the register/arithmetic-logic unit. The microcontrol portion includes a microstore of control words and a next state sequencer. Control words are fetched from microstore addresses as selected by the next state sequencer. Microstore addresses may be generated by incrementing, branching, etc., the next state sequencer being directed by a portion of the control word and by the logic level of a test input.

The microcontrol portion has to set up the next control word as quickly as possible, but otherwise stay out of the way, allowing the register/ALU portion to run at its maximum speed.

Today, this is not as easy as it was in the past. With LSI register/ALU units, such as the IDM2901A-1 or the IDM2901 , capable of speeds in the 100 to 125 nanosecond range, even the most complicated operations, such as multiply and devide, are fast enough to push most present day microcontroller designs approaches to their limits. Therefore other, higher speed approaches must be considered to take full advantage of the higher speed register/ALU's.

The first approach to microprogrammed system design — the very earliest use of state sequencing was utilized in early minicomputers and even some larger systems. Operations were performed in series, one after another (Figure 1 Phase I), with the microcycle being defined as the sum of the separate sequencer and register/ALU operations.

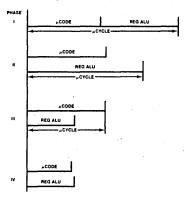


Figure 1. History of the µCycle

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This solution, still in use today in some designs, routed controller timing from the clock edge of the controller register/counter through microcontrol storage, through the processing elements, then back through the next state decision tree to the controller register/counter.

The second approach, called pipeline microcoding, is an approach commonly used in bit slice systems. In this solution the microcontroller loop timing operates in parallel with the execution of the processing component section (Figure 1 Phase II). During the time an arithmetic/logic operation is performed, the next microcontrol word is being accessed. The microcontrol word for the present register/ALU operation had been selected and accessed during the previous microcycle, and is currently held in a pipeline register.

This type of microsequence control results in a faster machine cycle than is achievable in the totally serial mode employed in the first approach. It may not however, achieve machine cycle times consistent with the register/ALU cycle times available with today's higher speed register/ALU elements. For example, using highspeed components, such as the IDM2900 family, results in a 65 to 70 percent improvement in the register/ALU path. In spite of this, the resultant total microcycle time may be reduced only 30 to 50 percent because the microcycle is determined by the duration of the longest operation, which, in this case, is the delay required by the microcontrol portion (Figure 1 Phase III). Circuits optimized to approach the register/ALU cycle time (Figure 1 Phase IV) are required.

Another problem associated with pipelining is that it also requires absolute knowledge of the next state control one cycle before the execution of the current register/ALU cycle. Therefore, it is difficult to implement successive conditional next state decisions which require a test of current register/ALU results. This problem will also be considered.

As will be shown, different circuits may be configured to minimize microcontrol delay while retaining the benefits of bit slice use. While the pipelining approach will be used throughout, the circuits will differ in the manner in which conditional branch control is achieved. Speed and parts count are traded off, while retaining the same microsequencing instruction set.

Three modes of executing conditional branches are covered:

- Overlapping the conditional branch propagation with the execution of a next unconditional microinstruction and using a NOP microcycle whenever useful work cannot be done in parallel (a NOP is a No OPeration microcycle during which the register/ALU is prevented from changing its contents). Conditional and unconditional microcycle times are equal.
- Using the same sequences as above but employing different microcycle durations; a shorter one for unconditional microinstructions and a longer one to allow for the propagation of conditionals.
- The pipelining prediction mode, where the conditional branch test is overlapped with the propagation of its statistically most likely outcome. Should this prediction prove to be true, the sequence continues; if false, a "pipeflushing" (NOP) one-cycle

time delay is employed, during which the correct control word is allowed to propagate to the microcontrol output.

#### **BASIC CIRCUIT ASSUMPTIONS**

In all cases it is assumed that the machine has a 16-bit register/ALU and a 12-bit microaddress. Changing these parameters may increase or decrease the relative value of a given circuit.

The following constant time delays will be assumed in all circuits:

#### 1. Microstore Time Delays

A microstore access time of 50 ns and a pipeline register setup time of 5 ns are assumed. (This is the minimum time required between microaddress validation and clocking the pipeline register).

#### 2. Microsequencer Time Delays

The "select address" propagation time of the microsequencer is the time interval begining when the select lines become valid and ending when the desired microaddress is available at the microsequencer's outputs. Using the high speed IDM2909/11A, a select time of 30 ns is guaranteed along with a 45 ns clock to output (from file) time.

Thus, the longest total path for the microstore plus the microsequencer is:

$$50 + 5 + 45 = 100 \, \text{ns}$$

This delay represents the calculated limit of the minimum time required to perform any unconditional sequence.

The setup time required by the microsequencer's internal registers is easily met in a 12-bit configuration, since it calls for a delay time of

$$(S_0S_1 \text{ to } C_{n+4}) + (C_n \text{ to } C_{n+4}) + (C_n \text{setup}) = 68 \text{ ns}$$

which is overlapped by the delay required between  $S_0S_1$  and the next system clock.

The condition-test time delay is circuit dependent and will determine how fast, or how slow, the circuit will go.

This delay includes: 1. the time required for the pipeline register to become valid from clock; 2. the selection or propagation of the status bit under test; 3. the negation or assertion of its polarity, and; 4. the translation of the test result and conditional branch data to code compatible with driving the microsequencer.

Since the choices in selecting fast microsequencers and microstores are severely limited, the condition-test circuitry becomes the prime candidate for user optimized logic designs, because it is simple and inexpensive, etc. The following circuits attempt to minimize, in different ways, the "delay" overhead caused by the next state decision. To gain a measure of their relative speeds, the delays are compared to the calculated minimum for unconditional sequencing,

which is 100 ns. A figure of merit is derived by dividing the total time delay by 100 ns minimum (Table 2).

Table 2. Microcontrol Circuits Comparison

Circuit	Dynamic Performance	Figure of Merit	Parts Count	Relative Cost
1	158 ns	58%	61/4	1.00
11	(Note 1)	(Note 1)	31/4	1.72
- 111	117/166 ns	17%/66%	71/4	1.12
l IV	114/135 ns	14%/35%	71/4	1.10
V	.133 ns	33%	7 <sup>2</sup> /3	0.96
VI	108 ns	8%	53/4	0.90
VII	108 ns	8%	61/4	0.97
VIII	108 ns	8%	7	1.06

Note 1: The presently (October 1978) available 2910 has a published guarantee of 100ns from clock to Y output on instructions 8, 9 and 15.

The longest data path has not been released. It occurs where prior instructions were 4 or 12 or RLD was low.

The currently available 2910 will need a 207 ns cycle when used in Circuit II in order to accommodate its longest data path (using calculated guarantees based on lab measurements performed on a number of parts). The corresponding figure of merit is 107%.

National Semiconductor's IDM2910A will need a 133ns cycle in the same circuit for its longest data path. The figure of merit will be 33%.

The IDM2910A will become available during the third quarter of 1983.

#### CIRCUIT I

This circuit is the traditional approach to the implementation of the microcontrol loop in a pipelined

configuration. Status outputs of the last register/ALU operation determine the micro-control word to be used for the next register/ALU operation.

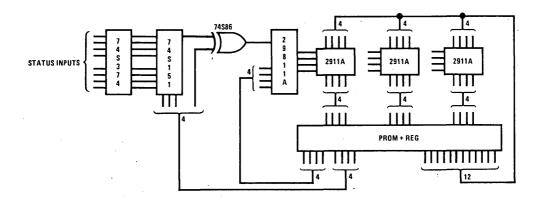
An IDM29811A next address controller is used to apply next address control to the IDM2911A four-bit microprogram sequencers. The IDM29811A is controlled by four pipeline register bits and one test input. The line to be tested is selected by a 74S151 eight-bit MUX as determined by the pipeline register. The pipeline register also determines whether negation or assertion should be performed by the 74S86 XOR gate to make it compatible with 29811 logical requirements.

The lines to be tested (inputs to the MUX) may be the results of a varity of functions internal or external to the controller. One line is generally tied to a permanent logic "1" or "0" so that by selecting it, the pipeline register may generate unconditional control of the 2911A. Some of the tested lines may carry data generated towards the end of the microcycle, such as ALU status. These data are stored in a 74S374 TRISTATE® octal D type flip-flop since it has to be used in the next microcycle.

Conditional microcycles may be either overlapped with useful work (microprogram permitting) or may be waited out by means of a NOP. Total microcycle length required by this microsequencer is 158ns and the figure of merit is

$$\frac{158-100}{100}$$
= 58%

A comparison between this microcycle time (158 ns) and the register/ALU loop time of 125 ns or 105 ns for the IDM2901 or IDM2901A-1, respectively, reveals that the machine's speed is limited by the microcontrol circuit. In short, even though the fastest microsequencer component (IDM2911A) was used, this traditional approach to microsequencer design is not compatible with higher speed, state-of-the-art ALUs.



Microcontroller, Circuit I

#### CIRCUIT II

One immediate "solution" to the problem outlined above, that has been suggested by some manufacturers, is going to a higher level of device integration, such as the 2910, which is a 12-bit microprogram sequencer designed to replace the 2911A and 29811A.

Conditional microprogramming is achieved here in the same way as in Circuit I and the parts count is reduced by 50%. However, the longest delay path is the one from the clock through the register/counter load to output — a guaranteed value of about 100ns. Microcycle time of this circuit is 207ns,\* its figure of merit is 107% which is worse than the circuit it was designed to replace. The reduction in parts count, however, may be beneficial in those applications where operating speed is less important.

#### CIRCUIT III

This circuit utilizes two different clock cycle periods: a short one for unconditional sequencing and a longer one for conditional sequencing. A 74S157 quad two to one MUX and one additional pipeline register bit are used in order to provide faster, unconditional next address control for the 2911As. When conditional control is required, the path selected by the 74S157 will go through the 29811A. The four pipeline register lines will switch from carrying 2911A code (unconditional) to carrying code needed for the 29811A. Conditional microcycles need to be achieved by a clock extended microcycle which can either be overlapped with useful work or waited out with a NOP.

Total unconditional microcycle time is 117ns and the figure of merit is 17%. For the conditional microcycle mode, total time is 166ns and the figure of merit is 66%.

The overall figure of merit can be determined by weighting the calculated percentages according to the relative dynamic frequency of conditionals.

#### **CIRCUIT IV**

Similar to Circuit III, this circuit differs only in the replacement of the 29811A and the 74S157 with two 74S158 quad two line to one line multiplexers. Inverting outputs have been chosen to gain speed.

Two 4-bit pipeline register fields are supplied to the condition selected 74S158, one of which is used in unconditional microsequencing by the 74S158 that drives the 2911A.

This solution produces cycle times of 114ns and 146ns and figures of merit of 14% and 46% respectively, for the unconditional and conditional next state cycles.

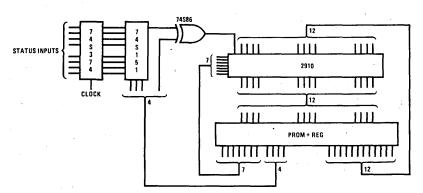
Now, by positioning the contents of the two 4-bit pipeline fields according to the logic level expected on the line under test, it is possible to remove the 74S86, eliminate one pipeline register bit to save 11 ns on the conditional next state cycle. This reduces the time to 135 ns and the conditional figure of merit to 35%. The unconditional figure of merit is unchanged (14%). Microprogramming is similar to that of Circuit III.

Another variation of this circuit is possible by removing the 74S158 driving the 2911A and connecting the outputs of the remaining 74S158 to the 2911A. The 74S86 may also be removed since the two, 4-bit pipeline register fields can be positioned to anticipate the desired result. Unconditional microcontrol is achieved by placing the same data on both sides of the 74S158. Total microcycle time is 129ns for both conditionals and unconditionals and the figure of merit is 29% (Compare this to the constant-microcycle time Circuit I. and II). Microprogramming is the same as in Circuit I.

#### CIRCUIT V

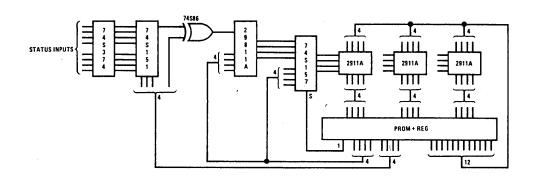
This circuit illustrates in yet another way the flexibility and advantages obtained by mixing MSI and SSI, in this case replacing the 74S158's used in previous circuits with 74S151's. Total timing needed is 133ns with a figure of merit of 33%.

This circuit is included to demonstrate a principle: sometimes a faster dynamic performance can be obtained by not using more complex circuits, in this case PROMs (29811A) and multiplexers. This occurs because less complex circuits allow greater freedom of design as well as being faster. Complex circuits may be slower and they frequently "force" design solutions to fit their own logical structure. Compare this circuit to Circuits, I, II and III.

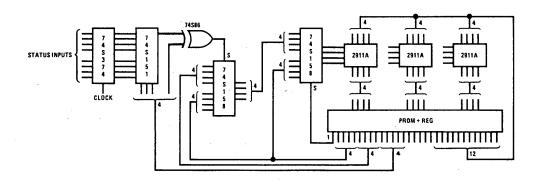


Note: Calculated guarantee based on lab measurements performed on a number of presently (October 1978) available parts. National Semiconductor's IDM2910A will show a significant speed improvement. (See Table 2.)

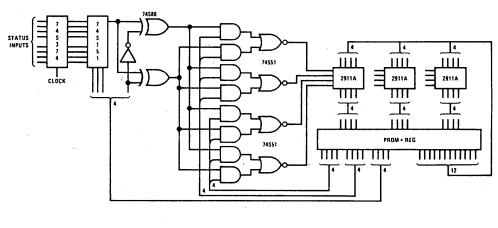
Microcontroller, Circuit II



Microcontroller, Circuit III



Microcontroller, Circuit IV



Microcontroller, Circuit V

#### CIRCUIT VI

This circuit represents a conceptual departure from the previous circuits. Although it functions in the same manner as the other circuits, here register/ALU performance is traded off in favor of the microcontroller loop. In other words, certain control loop time delays have been shifted over to the register/ALU loop. The status line to be tested is selected on the same microcycle that originated the status. One 74S74 edge triggered FF is used instead of the 74S374's which appear in the previous circuits.

In effect, the status register is now only one Flip-Flop of a faster varity than the 74S374's and less expensive relative to package count. If unconditionals are performed by setting the two 4-bit pipeline register fields to be identical to each other, the 74S86 may be removed as in Circuit IV.

Microcycle time is 108ns and the figure of merit is 8% for both conditional and unconditional sequences. It should be remembered, however, that 15ns has been inserted into the register/ALU loop. Using the 2901A-1, this 15ns must be added to the status valid time for a 16-bit addition of 82ns plus a 9ns clock-to-output pipeline register on the file addresses. This gives a total register/ALU microcycle time of:

$$82 + 9 + 15 = 106 \, \text{ns}$$

which is compatible with the 108 ns required for the microcontroller portion.

If the overall solution can be improved by moving time from one loop to another, the designer should do it.

Microprogramming this circuit is slightly different than the previous circuits since status generation and selection must be made during the same microcycle. Overlapping conditionals with useful work can be accomplished, or NOPs could be employed.

#### **CIRCUIT VII**

This circuit employs pipeline prediction to enhance speed in performing conditional microsequences.

Since in the other circuits outlined, the results of a register/ALU operation cannot be used to direct the operation immediately following it, it becomes necessary to insert fill-in words or NOPs. Pipeline prediction will minimize the number of NOPs required.

The term "prediction" refers to selecting and propagating the statistically most likely outcome. Should this prediction come true, the machine will continue at the unconditional microinstruction speed. If, however, the prediction turns out to be wrong, the predicted microcycle is converted to a NOP while waiting for propagation of the correct conditional outcome. During this waiting period the system will ignore the false microcontrol output word.

In this circuit, the prediction (and its correction, if necessary) are controlled by a 74S114 J-K edge triggered flip-flop. A logical zero result at the 74S86 output leaves the 74S114 in the "predict" position; a logical "one" causes the device to toggle and to apply to the 2911A the other choice of control code. This code is found in the 74S374, which is used as a one

microcycle delay in order to preserve the initial code during NOP execution. Microcode forces a zero logic level at the output of the 74S86 whenever unconditional microinstructions are used. This logic level, in turn, causes the 74S114 to remain in its "predict" state, which is also used to generate unconditionals.

With this design, it is possible to stack any number of conditional states next to one another without confusing the controller. If all the predictions are correct, the machine operates in half the number of cycle times than with the previous technique. If all the first choices were incorrect, the design still breaks even with the previous solutions.

Generally, a net savings of cycles will result, having the same effect as an additional microcycle time speedup. This, together with the employed single length clock, makes this a very attractive circuit.

Microprogramming this circuit resembles Circuit VI, except that a jump (JMP) may not be predicted if the other choice is a continue (CONT). Such a prediction would cause an irreversible change in the microprogram counter/register. Other changes that may occur in the 2911A stack or address register can be inhibited by using the "one" logic level at the 74S86 output as a means to inhibit the RE and FE lines.

Total microcontroller cycle time is 108ns and the figure of merit is 8%.

#### CIRCUIT VIII

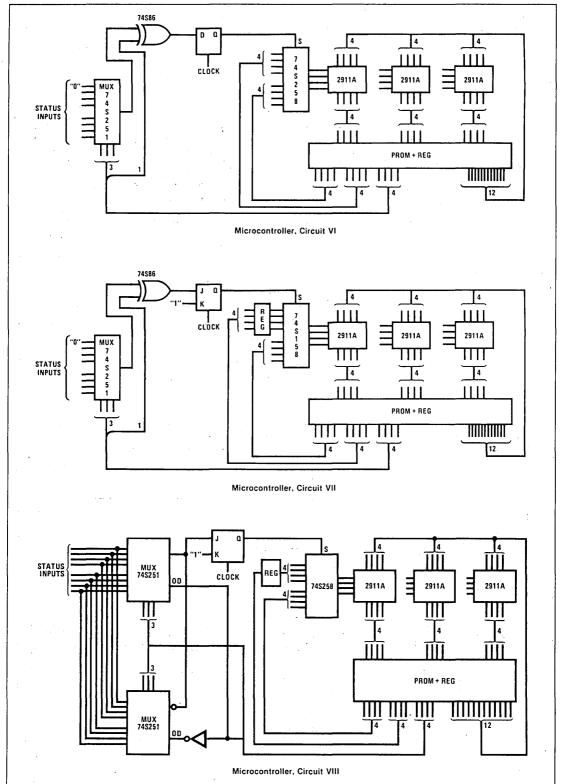
This circuit is essentially the equivalent of Circuit VII. Two 74S251 TRI-STATE® multiplexers have been used to decrease the propagation delay on the register/ALU side by eliminating the 74S86. Total time and overhead are unchanged (108ns and 8%).

#### CONCLUSION

In less than two years, the 2900 bit-slice family has improved microcomputer speeds by 50% to 70%. The IDM2901A-1, the fastest part available, allows controlling and number-crunching CPU designs demanding less than 100 ns per microcycle.

Faster microcontrol loops are required in order to take full advantage of ALU bit-slices like the IDM2901A and the IDM2901A-1.

A few fast microcontrol loop designs have been explored, using the versatile IDM2909A/2911A microsequencer. These circuits are offered as basic suggestions, and as starting points for specific designs. Since, among other things, the data word width, the instruction repertoire and microstore size of a CPU will strongly influence the choice of which microcontrol loop design is best suited to yield the desired speed, price, microprogramming features, etc., the final choice must be made by the designer of a specific system.



## Fine Tuning the ALU Carry Path

National Semiconductor Application Note 230 Harry Holt May 1979



Most applications information for the IDM2902 Look-Ahead Carry Generator Family show three standard connections for 16-, 32-, and 64-bit Arithmetic Logic Units (ALUs). The three methods are shown in Figure 1.

With ALU cycle times in the 200 ns area, the standard connections shown in Figure 1 were quite adequate. A 5 to 10 ns overall savings did not warrant the time spent to examine alternative look-ahead carry

methods. However, with the introduction in 1978 of the IDM2901A-1, cycle times began to approach 100 ns. This was further reduced to less than 80 ns (for a 16-bit ALU) with the introduction of the IDM2901A-2 in 1979. Now, obviously, a 5 to 10 ns savings is significant and well worth a new look at look-ahead carry techniques. The purpose of this application note is to do just that and, as will be shown, some of the results do not favor the standard approaches.

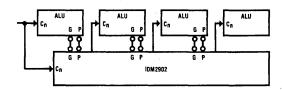


Figure 1(a). Conventional 16-Bit

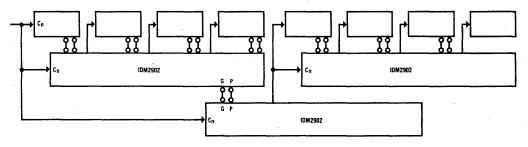


Figure 1(b). Conventional 32-Bit

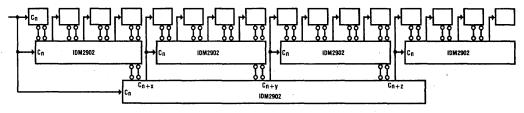


Figure 1(c). Conventional 64-Bit

#### **BASIC METHODS**

The basic methods examined in this application note can be divided into four categories:

- 1. Ripple Carry
- 2. Conventional Single Level
- 3. Multi-Level
- 4. Shifted

Ripple carry is generally considered to be slow, but at 8 bits it turns out to be the fastest method. Also, it will be shown that ripple carry can be used in combination with other methods to eliminate parts while adding very little to system cycle time. In most cases, the various methods will result in tradeoffs between parts count and system speed. It will be shown that some solutions, however, generate the highest performance with the fewest parts!

Single-level will be used to describe a system with a single layer of look-ahead carry even though technically this is a multi-level solution since the ALU itself looks across four bits. An example of a single-level approach is the 16-bit solution of Figure 1(a).

The conventional 32-bit connection [Figure 1(b)] is an example of multi-level look-ahead. In this approach, the carry-in is connected to two IDM2902s.

The least well known of the four methods is the shifted approach shown in Figure 2. Although this results in a slightly slower method in the 16-bit solution shown, there are word sizes where it can be the fastest method. Furthermore, freeing a set of G, P pins on the IDM2902 can have advantages in certain applications where sign-extension is required. (See Reference 1.)

As alluded to above, the various methods can be combined in a number of ways. The following is a list of the various combinations that were examined in this study. Almost all were applied to ALU sizes from 4 to 64 bits to identify the advantages and disadvantages of each. These will be summarized later.

#### Table I. Look-Ahead Carry Methods

- 1. Ripple
- 2. C<sub>n</sub>
- 3. Shifted
- 4. Chained
- 5. Shifted Chain
- 6. Two Level
- 7. Two Level with Helpers
- 8. Shifted Two Level
- 9. Shifted Two Level with Helpers
- 10. Double Shifted Two Level
- 11. Double Shifted Two Level with Helpers
- 12. Three Level
- 13. Shifted Three Level
- 14. Double Shifted Three Level

#### **FACTORS AFFECTING CHOICE**

Before applying the look-ahead carry methods to the various word length ALUs, it may be worthwhile to look at some of the factors — other than raw speed — that could affect the choice of method. Some of these are:

- 1. parts count
- 2. board-to-board considerations
- 3. board space
- 4. sign extend
- 5. sequencer cycle time
- 6. board layout
- 7. word length expansion
- 8. different system architectures
- 9. current spiking

While parts count, board space, and board layout are more or less obvious considerations, the others deserve a brief comment:

- A. Board-to-board considerations refer to those systems where half of the ALU is on one board and half is on another. Obviously all methods would not be readily adaptable to this situation if a sufficient number of connector pins is not available.
- B. Sign-extend requirements may favor the method that frees a G,P input on one of the look-ahead carry circuits. This is explained more fully in Reference 1.
- C. Sequencer cycle time, in a pipelined system, may be the limiting factor in overall system speed. Thus, saving a few nanoseconds in the ALU may not be worthwhile.
- D. Future word length expansion is a consideration if several models of the same basic system are required. For example, 16 bits of address can address 64K words; twenty bits can address 1M words. If the ALU is used to compute addresses, the carry method optimized for 20 bits may be desirable.
- E. The architecture that was assumed for this study will not be used in every system. Thus, the availability and timing of input signals, worst-case delay paths, and added components will affect the results shown in the following section. Thus, each design could require a separate study to achieve optimized results.
- F. Current spiking is a consideration when one method causes several ALUs to change output states within a few nanoseconds of each other. If this causes system noise problems, perhaps an alternate method would be desirable.

#### **APPLYING THE VARIOUS METHODS**

In the following discussion, the IDM2901A-1 timing is used for the register-ALU elements. Because several different choices of pipeline register are available, the times shown do *not* include the clock-to-register output delay. Finally, the comparisons are based on the time required to add two registers and obtain a valid output, i.e.,  $A+B \rightarrow Y$ .

**4,8 Bits:** Ripple carry is clearly the best from all considerations and thus no further discussion is necessary. Register-to-register add time for 8 bits is 75ns.

**12 Bits:** At present, the conventional single-level method is best (77 ns). However, if future bit-slices feature A, B  $\rightarrow$  C<sub>n+4</sub> as fast as A, B  $\rightarrow$   $\overline{G}$ ,  $\overline{P}$  and C<sub>n</sub>  $\rightarrow$  C<sub>n+4</sub> as fast as the IDM2902's  $\overline{G}$ ,  $\overline{P} \rightarrow$  C<sub>n+y</sub>, ripple carry can be just as fast. (This illustrates the need for designers to continually rethink the problem as new parts become available.)

16 Bits: Without considering sign extend, the conventional approach [Figure 1(a)] is optimum (75ns). The shifted method (Figure 2) is 8.5ns slower under the assumptions made above, but if sign extend is required,

Note: In the figures that follow, connecting lines are simplified and terminal labels are eliminated for clarity.

it may well be as fast, in addition to eliminating multiplexers. (See Reference 1.) (This illustrates the fact that two parts of a system optimized independently may result in an overall slower system.)

20 Bits: As word width increases above 16 bits, some of the less conventional approaches begin to have some advantage. First, consider the more obvious approaches; the single level and chained approaches are shown in Figures 3(a) and 3(b). Another solution can be obtained by deleting parts from the conventional 32-bit solution of Figure 1(b). This is shown in Figure 3(c).

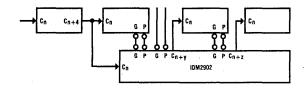


Figure 2. 16-Bit Shifted Look-Ahead

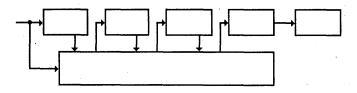


Figure 3(a). 20-Bit, Single-Level Method

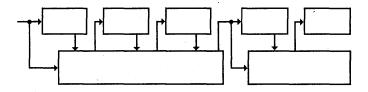


Figure 3(b). 20-Bit, Chained

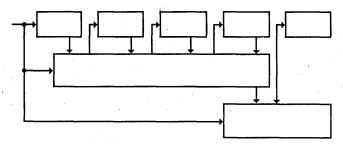


Figure 3(c). 20-Bit, Two-Level

From a timing standpoint, (b) and (c) of Figure 4 are both 87.5 ns compared to 93 ns for (a). The single-level method [Figure 3(a)] is superior from a parts count standpoint, requiring a single look-ahead carry rather than two. A closer look at Figure 3(c), however, reveals that only a small portion of the second look-ahead carry circuit is used. Furthermore, this portion can be replaced by a circuit consisting of 1/6 of a 74S04 and 1/2 of a 74S51 as shown in Figure 4. In addition to a lower power, lower cost solution, the replacement of the second look-ahead carry circuit actually saves 1.5 ns!

Even more surprising is the fact that the shifted method shown in Figure 5 not only has the fewest parts, but also runs faster (85.5ns) than the other methods shown. Here is a situation where the speed-cost tradeoffs BOTH favor the same solution!

24, 28 Bits: Using the conventional 32-bit solution (deleting one or two ALUs) yields identical times (98 ns) for both 24 and 28 bits. The shifted chain (Figure 6), however, uses fewer parts and is faster (96 ns). With the same parts count, the chained and two-level methods yield the fastest times (87.5 ns) for both 24- and 28-bit ALUs.

32 Bits: The conventional approach for 32 bits shown in Figure 1(b) is an example of the two-level with helpers method. For 32 bits, the register-to-register add time is 98 ns for this method. This is a faster approach than the chained and two-level methods (103.5 ns) that were optimum for 24 and 28 bits. Another method — the

shifted two-level — again uses fewer parts and is considerably faster than the conventional approach (87.5 ns). This is illustrated in Figure 7.

**36, 40, 44 Bits:** A 98ns solution can be obtained for 36-bit ALUs by simply deleting parts from the 64-bit solution of Figure 1(c). A word of caution: this is *not* the path to the most significant slice (MSS). It turns out that this path is only 87.5 ns. The 98ns path is to the output of the second MSS. The shifted two-level with helper method (Figure 8) will also produce a 98 ns result, but if the "helper" is replaced by the circuit of Figure 4, the result is 96.5 ns.

Another solution, requiring only two parts, is shown in Figure 9. This solution — the double shifted two-level method — turns out to be the best two-part solution for all word sizes from 36 to 64 bits. Speed for this method is 101.5 ns.

The shifted two-level with helper and double-shifted two-level methods turn out to be the optimum three-part and two-part solutions for 40- and 44-bit ALUs also.

48 Bits: As mentioned above, the double shifted two-level method shown in Figure 9 is also the optimum two-part solution for 48 bits. Three-part solutions are shown in Figure 10. The shifted three-level solution of Figure 10(a) results in a 114ns system. The double shifted three-level solution is 101.5 ns. Note how the worst-case path varies between the two solutions. This points out the fact that several paths must be evaluated to ensure that the longest one has been found.

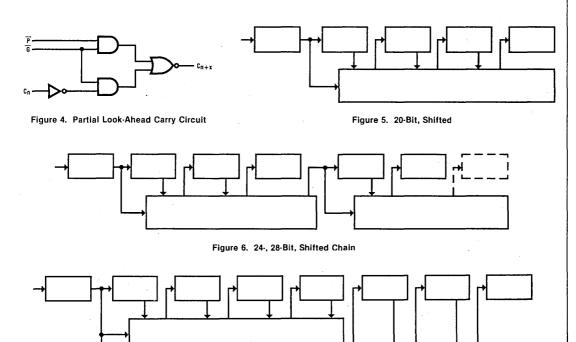


Figure 7. 32-Bit, Shifted Two-Level

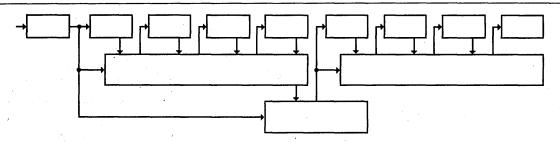


Figure 8. 36-Bit, Shifted Two-Level with Helper

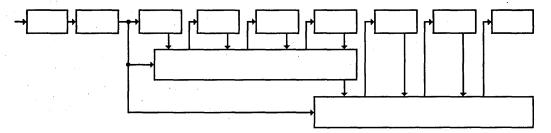


Figure 9. 36-Bit, Double-Shifted, Two-Level

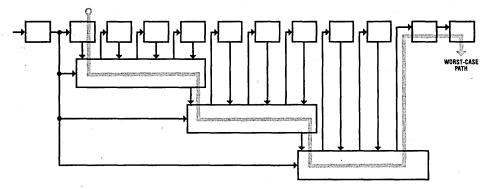


Figure 10(a). 48-Bit, Shifted, Three-Level

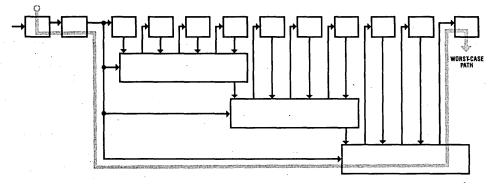


Figure 10(b). 48-Bit, Double Shifted, Three-Level

The four-part system of Figure 11 improves performance slightly (98ns) and may not be worth the additional expense. It is, however, the best four-part choice from 48 to 60 bits. This method is referred to as shifted two-level with helpers.

**52 Bits:** Not a particularly popular ALU size, the 52-bit system nevertheless provides an opportunity to demonstrate another look-ahead carry method — the double-shifted, two-level with helpers. This also turns out to be the fastest three-part method for word widths from 52 to 64 bits. This.method, illustrated in Figure 12, results in 117.5 ns for 52-bit systems.

**56 Bits:** ALUs of 56 bits are becoming common in floating point systems using 56 bits of mantissa and 8

bits of exponent. Deleting components from the conventional 64-bit approach [Figure 1(c)] results in a 98ns solution. This same speed, however, can be achieved with four parts using the shifted two-level with helper method of Figure 13.

**60 Bits:** The fastest 60-bit solution is the conventional approach for 64 bits [Figure 1(c)] with one alu deleted. This results in a 98 ns solution. The shifted two-level with helper method (Figures 11 and 13) is a four-part solution that results in 103.5 ns.

**64 Bits:** Again, the fastest 64-bit solution (98ns) is the conventional approach of Figure 1(c). The fastest fourpart solution is a double-shifted two-level with helper method (117.5ns) illustrated in Figure 14.

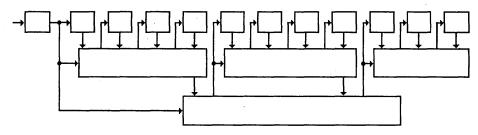


Figure 11. 48-Bit, Shifted Two-Level with Helpers

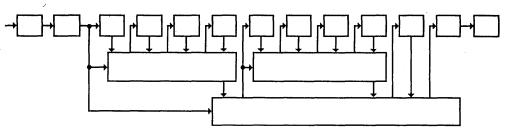


Figure 12. 52-Bit, Double-Shifted, Two-Level with Helpers

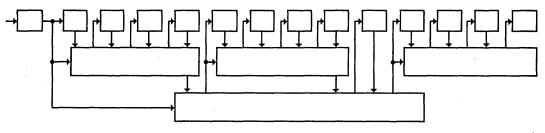


Figure 13. 56-Bit, Shifted, Two-Level with Helper

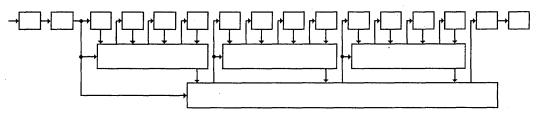


Figure 14. 64-Bit, Double Shifted, Two-Level with Helper

Table II is a summary of the data generated from this study. It lists, for each word size, the fastest solution for look-ahead carry parts count from 0 to 5. The number

under the "Method" column corresponds to the numbered list of Table I. The fastest solution for each word size is shaded.

. Table II. Optimum Speed for 4-64-Bit ALUs

	L			_	N	umber o	IDM2902	5				
Word Size Meth	0	0 1			2		3		4		5	
	Method	Time	Method	Time	Method	Time	Method	Time	Method	Time	Method	Time
.4	1	50									1	
8	1	75										
12	1	91	2	77								
16	1	107	2	77								
20	1	123	3	85.5	4	87.5						
24	1	139	3	101.5	4, 6, 8	87.5	. 7	98				
28	1	155	3	117.5	4, 6, 8	87.5	9	98				
32	1	171	3.	133.5	8	87.5	9	98				
36	1	187	3	149.5	10	101.5	7, 9, 12	98				
40	1	203	.3	165.5	10	117.5	4, 7, 9, 12	98				
44	1	219	3	181.5	10	133.5	9, 13	98				
48	1	235	3	197.5	10	149.5	14	101.5	7, 9	98		
52	1	251	3	213.5	10	165.5	11 ·	117.5	7, 9	98		
56	1	267	3	229.5	10	181.5	11	133.5	9, 13	98	7	98
60	1	283	3	245.5	10	197.5	11	149.5	9	103.5	7, 9	98
64	1	299	3	261.5	10	213.5	11	165.5	11	117.5	7, 9	98

#### CONCLUSIONS

It may appear that a lot of time was spent investigating alternate look-ahead carry schemes that save "a few nanoseconds" in overall speed. While this is certainly true for systems with ALU cycle times in the 200ns range, it has been shown that with the more recent 2900 components from National Semiconductor, ALU cycle times in the 100ns region are certainly feasible, and here those same few nanoseconds could become significant. This will be even more apparent with the introduction of the IDM2901A-2, which will improve the register/ALU times listed in Table III by another 20–25%.

It has also been shown that no one solution is "best" for all applications. Even the "fastest" solution may not be optimum for a specific system when parts count, system wiring, board space, etc., are considered.

Table III. Delay Times Used to Calculate Cycle Time

IDM2901A-1:		IDM2902:
AB → Y	.50 ns	$\overline{G}, \overline{P} \rightarrow \overline{G}, \overline{P} \dots 10.5 \text{ ns}$
AB → G, P	. 45 ns	$C_n \rightarrow C_{n+x,y,z} \dots 10.5 \text{ ns}$
$AB \rightarrow C_{n+4} \dots$	.50 ns	$\overline{G}, \overline{P} \rightarrow C_{n+x,y,z} \dots .7.0 \text{ ns}$
$C_n \rightarrow C_{n+4} \dots$	.16ns	•••
$C_n \rightarrow Y$	.25 ns	

Finally, the entire study will soon be obsolete as new components with different (albeit faster) specifications are introduced. Therefore, the only conclusion that seems legitimate is that each application should be considered individually with the requirements of the system, the devices available, and sound engineering judgement determining the optimum solution. It is hoped that the information contained in this application note will provide some guidelines for finding that solution.

#### REFERENCES

- AN-203, Bit-Slice Microprocessor Design Takes a Giant Step Forward with "Schottky-Coupled-Logic" Circuits.
- AN-217, High Speed Bit-Slice Microsequencing Design.



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# National Semiconductor

#### **Programmable Logic**

#### **Introduction And General Description**

#### What is a PAL?

A PAL is a user-programmable array of logic gates which allows the equivalent of a number of SSI and MSI (small- and medium-scale integration) packages to be implemented on a single chip. NSC's PAL series are Schottky TTL (transistor-transistor logic) components, and hence offer both speed and easy interfacing. Combinations of registers, flip-flops, and random logic are all easily implemented using PALs.

#### Why Should You Use A PAL?

#### Reduced board space

PALs typically implement the equivalent of from 4 to 12 SSI and MSI packages in a single 20-pin DIP. If the amount of space on your PCB is insufficient for your needs, you should seriously consider using PALs in your design.

#### **Cost Effectiveness**

The total manufacturing cost of a circuit implemented with PALs is frequently less than that of standard ICs. Only 25 to 50 per cent of the cost of utilizing an SSI or MSI chip is normally its purchase price; the remaining 50 to 75 per cent is tied up in the cost of the PCB area, assembly, and testing associated with that chip. Hence, as the PAL replaces more and more chips, its usage quickly becomes justified on a cost basis alone.

#### Fast System Design

Because of PALs' programmability and flexibility, the time needed to design and implement a system can be cut in half. Breadboards can be built quickly to test out new ideas without long waiting.

#### **Design Flexibility**

PALs offer the design engineer greater flexibility than standard, off-the-shelf parts. If a desired function is not readily available with standard components, an awkward assortment of chips may be needed to implement the function. With PALs, the engineer simply chooses what he wants instead of taking what he can get.

#### Easy Design Changes

PALs offer the designer the ability to reprogram an IC instead of redesigning other hardware and laying out a new PCB when the function of the card changes.

#### High Speed

PALs are built using Schottky technology. Register PALs clock at 40 MHz, with faster parts on the way.

#### **Easy Field Programming**

Unlike gate arrays and other approaches to custom logic design, the PAL is user-programmable, which minimizes turnaround time. The PAL can be programmed quickly and easily using standard PROM programmers with appropriate personality cards. Conversion of logic functions into the PAL format is accomplished quickly and easily using a software tool called PALASM<sup>TM</sup>

#### **Small Inventory**

The PAL family can be used to replace up to 90 per cent of TTL components with just 15 different parts. This considerably lowers inventory costs.

### What Is The Impact Of PAL On Logic Design?

Logic designers are noticing an apparent "complexity gap" between TTL and LSI. Products designed using discrete TTL devices would consume unacceptable amounts of physical space and electrical power. Software programmable LSI devices (microprocessors) offer high density and need relatively little power to do almost anything imaginable, but the designer pays a high price in software development and still has to use discretes to interface them to the outside world. Until recently, there has been no device that provides a really effective way of bridging this gap. National Semiconductor Company has seen this need, and now offers the designer a family of PAL (Programmable Array Logic) devices to fill it. PALs offer powerful capabilities for

creating cost-effective new products or for improving the effectiveness of existing logic designs. PAL devices save time and money by solving many of the system partitioning and interface problems not otherwise effectively solved by today's semiconductor device technology.

LSI (Large scale integration) offers many advantages, but advances have been made at the expense of either device flexibility or software complexity. LSI technology has been and still is leading to larger and larger standard logic functions. LSI offers high functional density and low power consumption; single ICs now perform functions that formerly required complete circuit cards. However, most LSI devices don't interface with user systems without large numbers of support devices. Designers are still forced to turn to random logic for many applications. LSI is slow, and it is rigidly partitioned. For all its capability to perform varied and complex tasks, the microprocessor is a slow and expensive way of doing simple, repetitive tasks when the necessary interface and other support devices are added, and when the time, money, and memory required for software development are considered.

TTL provides speed, and you could say its flexibility is infinite, but its price is high power consumption, large parts count, and low space utilization.

Custom IC's can be effective design solutions if the product is of low-to-medium complexity, its logic function is well defined, and its market is high volume. Its design cycle is typically long, and its cost can be prohibitive. This tends to discourage its use.

Fuse-programmable devices of various kinds have been invented to try to overcome the above-mentioned disadvantages. All but PAL require external interface logic, and all but PAL have disadvantages, to wit:

PROM: Requires careful design to avoid undesirable data transitions. Also limited on the number of input variables it can accommodate.

FPLA: Is expensive, difficult to program, and hard to understand.

FPGA: Isn't widely available, and lacks flexibility.

PMUX: Is available in only a few types.

## The PAL—A New Extension of Fusible-Link Technology

The diode matrix was the first programmable integrated-circuit logic device, introduced in

the early 1960's. This device contained only a diode-logic OR matrix, each crosspoint of which had a fusible link.

The programmable read-only memory (PROM) extended the programmable logic concept considerably by allowing input variables to be encoded, by reducing the number of pins required per input variable, and by providing TTL compatibility. The PROM is an AND-OR logic element with fixed AND matrix and programmable OR.

One advantage of using PROMS is that they are produced in high volume because they are used in many applications. Also, the PROM is a universal logic solution; in other words, all the product terms of the input variables are generated, making it possible to implement any AND-OR function of these variables.

The Field-Programmable Logic Array (FPLA) has a second fuse matrix (an AND matrix), so allows the designer to select and program only those product terms used in each specific function. These product terms are then combined in the OR fuse array to form an AND-OR logic equation. More about these later.

#### How It Works (See Figure 1-1.)

In the PAL concept, an AND fuse array allows the designer to specify the product terms required, and connect them to an OR matrix chosen to perform the required combination of AND-OR logic functions. PALs are offered in a number of different part types that vary the ORgate configuration. Specifying the OR-gate connection therefore becomes a task of device selection rather than of programming, as with the FPLA. With this approach, PALs eliminate the need for a second fuse matrix with little loss in overall flexibility. Figure 1 is a schematic diagram that shows how a typical PAL circuit processes a two-input, one-output logic segment. The general logic equation for this segment is:

Output = 
$$(I_1 \bullet f_1 + /f_1) (/I_1 \bullet f_2 + /f_2) (I_2 \bullet f_3 + /f_3) (/I_2 \bullet f_4 + /f_4) + (I_1 \bullet f_5 + /f_5) (/I_1 \bullet f_6 + /f_6) (I_2 \bullet f_7 + /f_7 + /f_7) (I_2 \bullet f_8 + /f_8)$$

where the "f" terms represent the states of the fuse links in the PAL's AND array. In the above equation, an intact fuse is represented by f = 1, and a blown fuse by f = 0.

Although logic equations are convenient for simple functions, they become progressively less tractable as the functions become more complex. In large systems, the logic diagram, or schematic, and the truth table are the methods more commonly used to describe

logic networks. For simplicity, PAL logic is described in this book using the symbolic notation shown at right in Figure 1-2. The conventional, combinational logic diagram of the same expression is shown at left. In the figure, an X represents an intact fuse which, in conjunction with the series diode (not shown schematically), performs the logical AND function.

The two-input, one-output example shown in Figure 1-1, redrawn using the new logic notation, is depicted in Figure 1-3.

Figure 1-4 is the normal combinational logic diagram of an example whose transfer function is as follows:

Output = 
$$I_1 \cdot /I_2 + /I_1 \cdot I_2$$

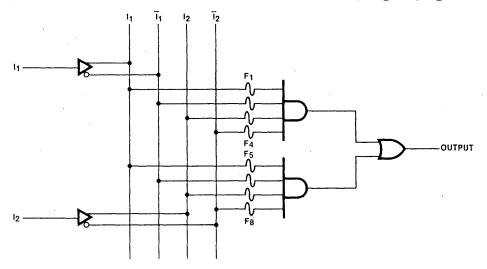


FIGURE 1-1. Partial Logic Diagram of a PAL®

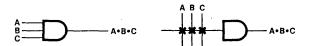


FIGURE 1-2. Conventional and PAL Logic Notation.

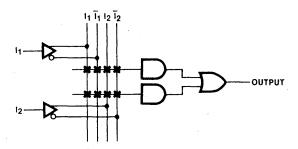


FIGURE 1-3. Two-input, One-output PALCircuit, Unprogrammed.

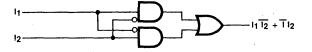


FIGURE 1-4. Logic Diagram of the Expression Shown Above

As can be seen from the expression and diagram, this is a two-input, one-output circuit; hence, the circuit of Figure 1-3 appears to be a good candidate to solve this problem. Removing the Xs from the junctions that do not represent terms of the example Boolean expression results in the diagram shown in Figure 1-5, which is the same PAL circuit shown in Figure 1-3, except that the appropriate fuses are blown.

Using the symbology described here not only displays the attributes of a logic diagram, but also those of the truth table for the same expression diagrammed. With this technique, it is possible to compare the structure of the PAL with those of the familiar PROM and PLA.

#### Comparison

To illustrate the differences among the three field-programmable logic concepts, each of the approaches is shown as an AND matrix, followed by an OR matrix. The basic logic implemented by the PROM is AND-OR, with the AND gates all preconnected on the chip, making this portion fixed, while the OR matrix is implemented with diode-fuse interconnections, making it programmable. Thus, the PROM is an AND-OR logic element with fixed AND matrix and programmable OR. The PROM solution in Figure 1-6 requires a 64-fuse matrix. There are many advantages to using PROMs as logic devices. One is that because they are used in many applications, they are produced in high volume. Also, the PROM is a universal logic solution; in other words, all the product terms of the input variables are generated, making it possible to implement any AND-OR function of these variables. However, PROMs cannot accommodate large numbers of variables; the maximum number of input variables currently being realized is 11.

The Field-Programmable Logic Array (FPLA) has a second fuse matrix (an AND matrix), allowing the designer to select and program only those product terms used in each specific function. (See Figure 1-7.) These product terms are then combined in the OR fuse array to form an AND-OR logic equation.

The typical FPLA implementation has less than  $2^n$  terms available (with n as the number of input variables). This allows the FPLA to accommodate larger values of n, i.e., more inputs, in contrast with the PROM, where the number of product terms is always equal to  $2^n$ . Although the FPLA usually requires fewer fuses to implement a given logic function, additional circuitry is required to select and program these fuses—circuitry that is not used in the final logic solution, but which is paid for in die area. This "chip overhead" cost becomes significant for simple applications that leave logic unused.

The basic logic structure of the PAL, consisting of a programmable AND array whose outputs feed a fixed OR array, is shown in Figure 1-8. The PAL is low in cost and easy to program, like the PROM, but also is more flexible, like the FPLA. Table 1-1 lists the characteristics of the three principal families of devices described here, and also others, for comparison.

Table 1-1.
Programmable Logic Device Summary

Device	AND	OR	Output Options
PROM	Fixed	Prog	TS,OC
FPLA	Prog	Prog	TS,OC,Fusible Polarity
FPGA	Prog	None	TS,OC,Fusible Polarity
PMUX	Fix/Prog	Fixed	TS
PAL	Prog	Fixed	TS,Registers,Feedback,I/O

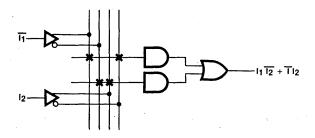


FIGURE 1-5. Blown Junctions Make the PAL Useful.

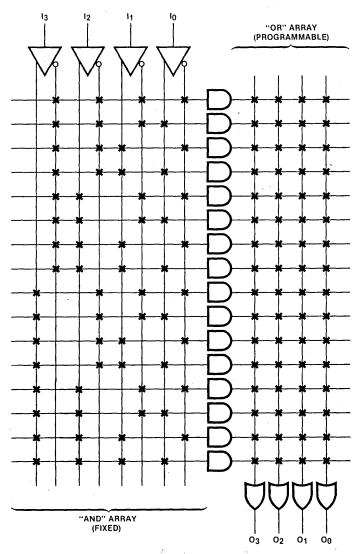


FIGURE 1-6. PROM Having 16 Words x 4 Bits.

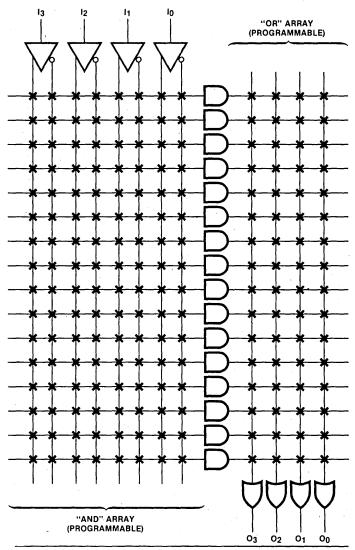


FIGURE 1-7. FPLA Having 4 Inputs, 4 Outputs, and 16 Products.

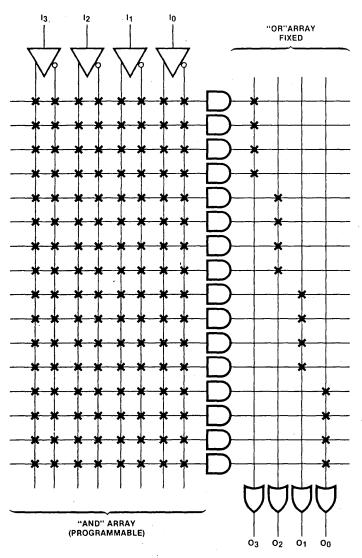


FIGURE 1-8. PAL Having 4 Inputs, 4 Outputs, and 16 Products.

TABLE 1-2. THE PROGRAMMABLE ARRAY LOGIC (PAL®) FAMILY

Std (35 ns)	High Speed (25 ns)	Pkg Pin	Description	
10H8	10H8A	20	10 input, 8 output AND-OR array	
12H6	12H6A	20	12 input, 6 output AND-OR array	
14H4	14H4A	20	14 input, 4 output AND-OR array	
16H2	16H2A	20	16 input, 2 output AND-OR array	
10L8	10L8A	20	10 input, 8 output AND-OR array	
12L6	12L6A	20	12 input, 6 output AND-OR array	
14L4	14L4A	20	14 input, 4 output AND-OR array	
16L2	16L2A	20	.16 input, 2 output AND-OR array	
16C1	16C1A	20	16 input, 1 output AND-OR/NOR array	
16L8	16L8A	20	16 input, 8 output AND-OR-invert array	
16R8	16R8A	20	16 input, 8 output AND-OR-register array	
16R6	16R6A	20	16 input, 6 output AND-OR-register array	
16R4	16R4A	20	16 input, 4 output AND-OR-register array	
16X4		20	. 16 input, 4 output AND-OR-XOR-register array	
16A4		20	16 input, 4 output AND-CARRY-OR-XOR register	
12L10		24	12 input, 10 output AND-OR invert array	
14L8		24	14 input, 8 output AND-OR-invert array	
16L6		. 24	16 input, 6 output AND-OR-invert array	
18L4		24	18 input, 4 output AND-OR-invert array	
20L2		24	20 input, 2 output AND-OR-invert array	
20C1		. 24	20 input, 1 output AND-OR/NOR array	
20L10		24	20 input, 10 output AND-OR-invert array	
20X10		24	20 input, 10 output AND-OR-XOR-register array	
20X8		24	20 input, 8 output AND-OR-XOR-register array	
. 20X4		24	20 input, 4 output AND-OR-XOR-register array	

#### **PALs For Every Task**

The members of the PAL family are listed in Table 1-2. They are designed to cover the spectrum of logic functions at lower cost and lower package count. This allows you to select the PAL that best fits your application. PALs come in four basic configurations:

- Gates
- Register Outputs With Feedback
- Programmable I/O
- Arithmetic Functions

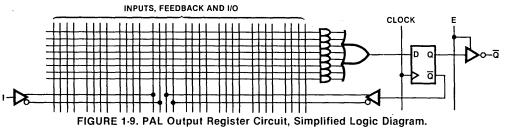
#### Gates

For 20/20A series, PALs are available in sizes from  $10\times8$  (10 inputs 8 outputs) to  $16\times2$ , with either active-high or active-low output configurations. For 24 series, PALs are available in sizes from  $12\times10$  to  $20\times2$  with active-low output configurations. One part has complementary outputs with both series. This wide variety of input/output formats allows the PAL to replace many different-sized blocks of combinational logic with single packages.

#### Register Outputs With Feedback

High-end members of the PAL family feature latched data outputs with register feedback. Each sum or product term is stored in a D flipflop on the rising edge of the system clock. (See Figure 1-9.) The Q output of the flip-flop can then be gated to the output pin by enabling the active-low TRI-STATE\* buffer.

In addition to being available for transmission, the Q output is also fed back into the PAL array as an input term. This feedback allows the PAL to "remember" its prior state, and it can alter its function based upon that state. This allows you to configure the PAL as a state machine that can be programmed to execute elementary functions such as count up, count down, skip, shift, and branch.



#### Programmable I/O

Another feature of the high-end members of the PAL family is programmable input/output. This allows the product terms to directly control the outputs of the PAL. (See Figure 1-10.) One product term is used to enable the TRISTATE\* buffer, which in turn gates the summation term to the output pin. The output is also fed back into the PAL array as an input. Thus, the PAL drives the I/O pin when the TRISTATE\* gate is enabled; the I/O pin is an input to the PAL array when the TRISTATE\* gate is disabled. This feature can be used to allocate available pins for I/O functions or to provide bidirectional output pins for operations such as shifting and rotating serial data.

#### **Arithmetic Functions**

The arithmetic functions add, subtract, greater than, and less than are implemented by two additional features of the register PAL. (See Figure 1-11.) First, the sums that are XORed at the input of a D flip-flop. This allows carries from previous operations to be XORed with current sums generated by the PAL array. Second, the Q output of the flip-flop is ORed with an input to form the terms I + Q, I + /Q, I+ Q, and II + IQ, which are then fed back into the PAL matrix. This option provides for versatile operations on two variables and facilitates the parallel generation of carries necessary for fast arithmetic operations. Figure 1-12 shows a PAL array, programmed to combine the available terms to form 16 logical products in an ALU or controller application.

#### Technology

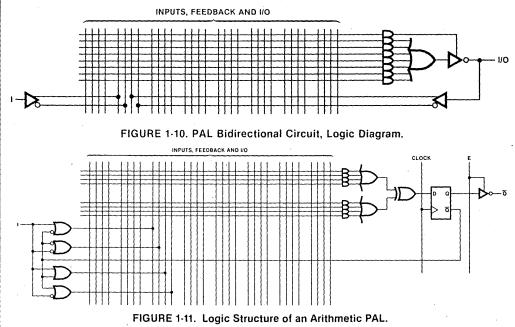
National Semiconductor PALs are manufactured using the same high-volume technology used in the manufacture of PROMs. This includes state-of-the-art Schottky processing, dual-layer metal, and highly reliable titanium-tungsten fuses. NPN emitter followers make up the programmable AND array. The inputs are PNP transistors whose input impedance imposes a current drain of not more than 0.25 mA on the source. All outputs are standard TTL drivers with internal active-pullup transistors. Typical PAL propagation delay is 25 ns for the standard version.

#### **Packaging**

All PAL versions are supplied in the spacesaving 20 and 24-pin, 0.3-in. "thin-dip" package. This package offers one of the best pin-countto-area ratios available.

PALS also utilize National's copper-lead-frame plastic package design that combines the low cost of plastic with the thermal characteristics of CERDIP to provide highly reliable, cost-effective components.

Programming PALs are designed to be programmed using standard, commercially available PROM programmers with the addition of the proper personality module and socket adapters. Some programmers with PAL programming capability are listed in the PAL Design section.





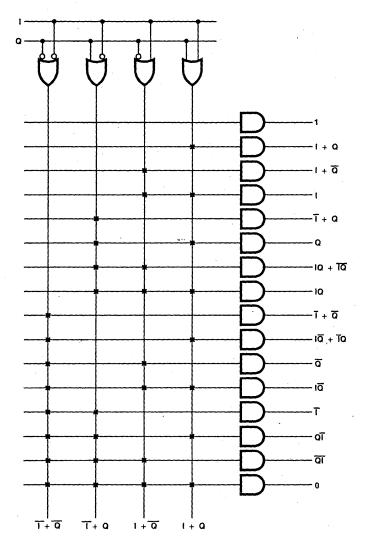


FIGURE 1-12. PAL Coding to Perform Typical ALU Functions.

#### **PAL Part Numbers**

The PAL part number reveals the logic operation the part performs. (See Figure 1-13.) The example shown, the DMPAL16L2NC, is a device that accommodates 16 input terms and

generates 2 active-low output terms, is contained in a 20-pin plastic dual-inline package, and meets commercial temperature-range specifications.

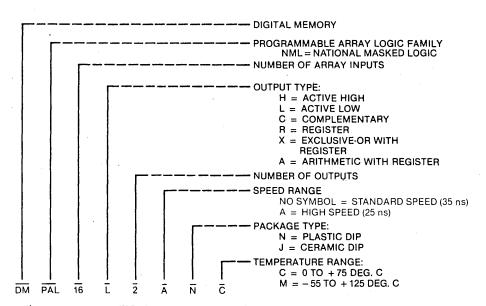


FIGURE 1-13. Meaning of PAL Part Number Code

#### **PAL Logic Symbols**

The logic symbols for each of the individual PAL devices gives a concise functional description of that device. Figure 1-14 shows a typical logic symbol, that of the 10H8 gate array.

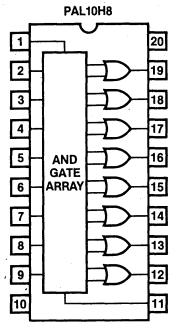
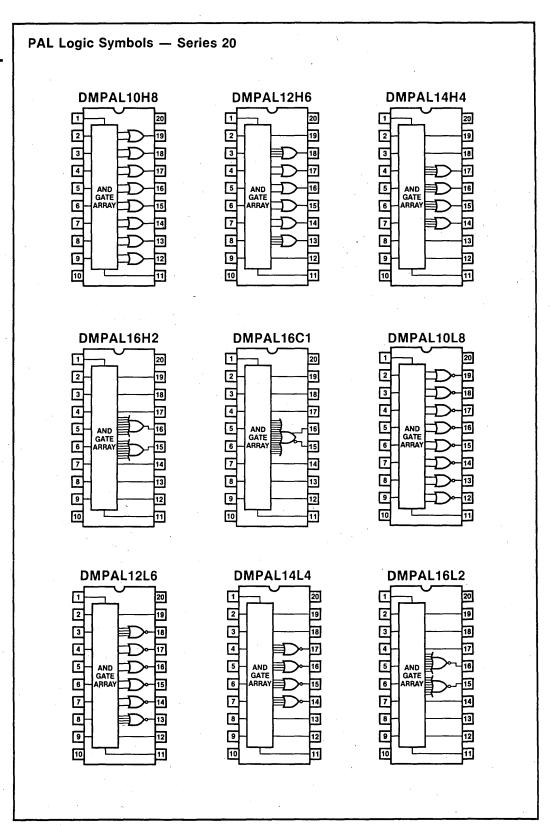
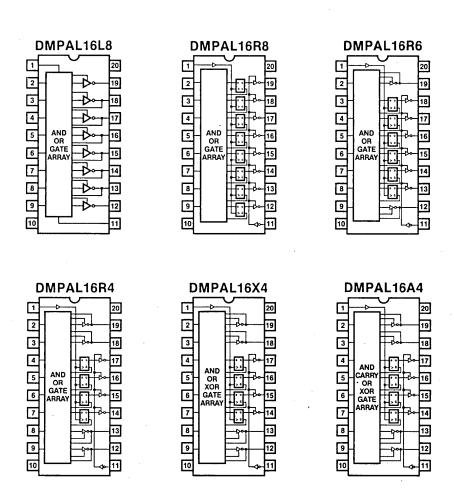


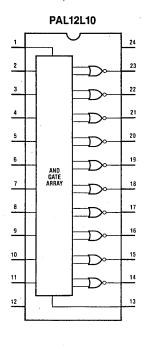
FIGURE 1-14. Logic Symbol, DMPAL10H8.

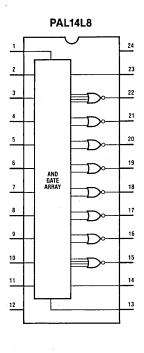


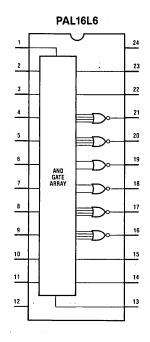
#### PAL Logic Symbols - Series 20 (Contd.)

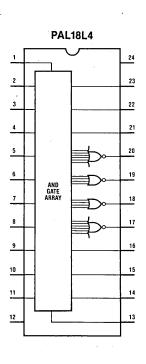


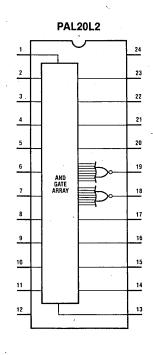
PAL Logic Symbols - Series 24

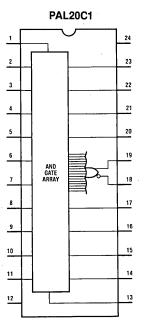


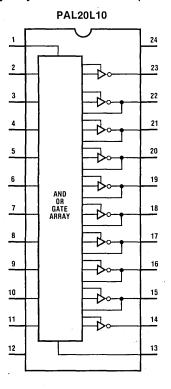


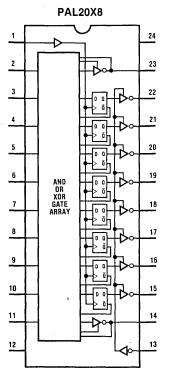


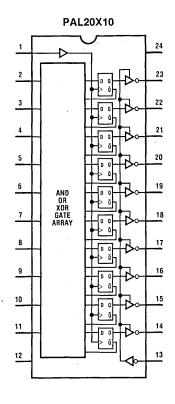


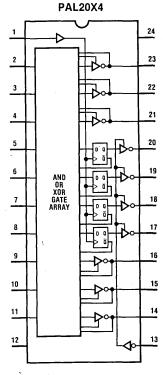












# National Semiconductor

# **Programmable Logic**

# **DATA SHEETS**

Programmable Array Logic (PAL®) Series 20/20A

#### Description

The PAL® family utilizes National Semiconductor's Schottky TTL process and bipolar PROM fusible-link technology to provide user-programmable logic to replace conventional SSI/MSI gates and flip-flops. Typical chip count reduction gained by using PALs is greater than 4:1.

The family lets the systems engineer customize his chip by opening fusible links to configure AND and OR gates to perform his desired logic functions. Complex interconnections that previously required timeconsuming layout are thus transferred from PC board to silicon where they can be easily modified during prototype checkout or production.

The PAL transfer function is the familiar sum of products with a single array of fusible links. Unlike the PROM, the PAL is a programmable AND array driving a fixed OR array. (The PROM is a fixed AND array driving a programmable OR array.) In addition, the PAL family offers these options:

- Variable input/output in ratio.
- Programmable TRISTATE® outputs.
- · Registers and feedback.

Table 2-1. Part Types

Part Number	Description
PAL10H8	OCTAL 10 INPUT AND OR GATE ARRAY
PAL 12H6	HEX 12 INPUT AND OR GATE ARRAY
PAL 14H4	QUAD 14 INPUT AND OR GATE ARRAY
PAL 16H2	DUAL 16 INPUT AND OR GATE ARRAY
PAL 16C1	16 INPUT AND-OR/AND-OR-INVERT GATE ARRAY
PAL 10L8	OCTAL 10 INPUT AND OR INVERT GATE ARRAY
PAL 12L6	HEX 12 INPUT AND OR INVERT GATE ARRAY
PAL 14L4	QUAD 14 INPUT AND OR INVERT GATE ARRAY
PAL 16L2	DUAL 16 INPUT AND OR INVERT GATE ARRAY
PAL 16L8	OCTAL 16 INPUT AND OR INVERT GATE ARRAY
PAL 16R8	OCTAL 16 INPUT REGISTERED AND OR GATE ARRAY
PAL 16R6	HEX 16 INPUT REGISTERED AND OR GATE ARRAY
PAL 16R4	QUAD 16 INPUT REGISTERED AND OR GATE ARRAY
PAL 16X4	QUAD 16 INPUT REGISTERED AND OR XOR GATE ARRAY
PAL 16A4	QUAD 16 INPUT REGISTERED AND CARRY-OR-XOR GATE ARRAY

Unused inputs are tied directly to  $V_{CC}$  or GND. Product terms with all fuses blown assume the logical high state, and product terms connected to both true and complement of any single input assume the logical low state. Registers consist of D type flip-flops that are loaded on the low-to-high transition of the clock. PAL logic diagrams are shown with all fuses blown, enabling the designer to use the diagrams as coding sheets.

The entire PAL family is programmed on conventional PROM programmers with appropriate personality and socket adapter cards. Once the PAL is programmed and verified, two additional fuses may be blown to make verification difficult. This feature gives the user a proprietary circuit that is very difficult to copy.

#### **Features**

- Programmable replacement for conventional TTL logic.
- Simplifies prototyping and board layout.
- Thin DIP packages.
- · Reliable titanium-tungsten fuses.
- Available in standard and high speed versions.
- 25 ns max propagation delay for high speed versions (20A series)

Part Number	Description
PAL10H8A	OCTAL 10 INPUT AND OR GATE ARRAY
PAL12H6A	HEX 12 INPUT AND OR GATE ARRAY
PAL14H4A	QUAD 14 INPUT AND OR GATE ARRAY
PAL16H2A	DUAL 16 INPUT AND-OR GATE ARRAY
PAL16C1A	16 INPUT AND OR/AND OR INVERT GATE ARRAY
PAL10L8A	OCTAL 10 INPUT AND OR INVERT GATE ARRAY
PAL12L6A	HEX .12 INPUT AND OR INVERT GATE ARRAY
PAL14L4A	QUAD 14 INPUT AND OR INVERT GATE ARRAY
PAL16L2A	DUAL 16 INPUT AND OR INVERT GATE ARRAY
PAL16L8A	OCTAL 16 INPUT AND OR INVERT GATE ARRAY
PAL16R8A	OCTAL 16 INPUT REGISTERED AND OR GATE ARRA
PAL16R6A	HEX 16 INPUT REGISTERED AND OR GATE ARRA
PAL16R4A	QUAD 16 INPUT REGISTERED AND OR GATE ARRA

# **Absolute Maximum Ratings**

	Operating	Programming
Supply voltage V <sub>CC</sub>	7.0 V	12 V
Input voltage	5.5 V	12 V
Off-state output voltage	5.5 V	12 V
Storage temperature range	– 65°C	to 150°C

### 10H8, 12H6, 14H4, 16H2, 16C1, 10L8, 12L6, 14L4, 16L2 **Electrical Characteristics**

Over Recommended Operating Temperature Range

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
V <sub>IH.</sub>	Ḥigh-level input voltage	-	2			٧
۷ <sub>IL</sub>	Low-level input voltage				0.8	V
V <sub>IC</sub>	Input clamp voltage	V <sub>CC</sub> = MIN I <sub>I</sub> = -18 mA			- 1.5	V.
v <sub>он</sub>	High-level output voltage	$V_{CC} = MIN$ $V_{IH} = 2V$ $V_{IL} = 0.8V$ $I_{OH} = MAX$	2.4			V
V <sub>OL</sub>	Low-level output voltage	$V_{CC} = MIN  V_{IH} = 2V$ $V_{IL} = 0.8V  I_{OL} = MAX$			0.5	V
l <sub>l</sub>	Input current at maximum input voltage	$V_{CC} = MAX  V_I = 5.5 \text{ V}$			1.0	mA
1 <sub>IH</sub>	High-level input current	$V_{CC} = MAX$ $V_{I} = 2.4V$			25	μΑ
اال	Low-level input current	$V_{CC} = MAX$ $V_1 = 0.4V$			_ 250	μА
los	Short-circuit output current	VCC = MAX VO=0V	- 30	,	- 130	mA
lcc	Supply current	V <sub>CC</sub> = MAX		55	90	mA

# **Recommended Operating Conditions**

Symbol	Parameter	Military			C	Unit		
		Min	Nom	Max	Min	Nom	Max	ļ
vcc	Supply voltage	4.5	5.0	5.5	4.75	5.00	5.25	٧
ІОН	High-level output current			2.0			- 3.2	mA
loL	Low-level output current			8			8	mA
TA	Operating free air temperature	- 55		125	0		75	•°C

Switching Characteristics Over Recommended Ranges of Temperature and  $\rm V_{CC}$ 

Symbol	Parameter	Test Conditions <sup>††</sup> R1 = 560Ω R2 = 1.1 kΩ	1 ~	Military - 55° to = 5.0V : Typ		TA	Commerc = 0° to = 5.0V Typ	75°C	Unit
t <sub>PD</sub>	From any input to any output	C <sub>L</sub> = 15pF		25	45		25	35	ns

# 16L8, 16R8, 16R6, 16R4, 16X4, 16A4 Electrical Characteristics Over Recommended Operating Temperature Range

Symbol		Parameter	Test Conditions	Min	Тур	Max	Unit
ViΗ	High-leve	input voltage		2 .			٧
VIL	Low-level	input voltage				0.8	٧
V <sub>IC</sub>	Input clar	np voltage	V <sub>CC</sub> = MIN I <sub>I</sub> = -18 mA			- 1.5	V
v <sub>он</sub>	High-level	output voltage	$V_{CC} = MIN  V_{IH} = 2V$ $V_{IL} = 0.8V  I_{OH} = MAX$	2.4			V
VOL	Low-level	output voltage	$V_{CC} = MIN  V_{IH} = 2V$ $V_{IL} = 0.8V  I_{OL} = MAX$			0.5	v
lozh		output current voltage applied	$V_{CC} = MAX, V_{IH} = 2V, V_{O} = 2.4V, VIL = 0.8V$			100	μА
lozL		output current voltage applied	$V_{CC} = MAX, V_{IH} = 2V$ $V_{O} = 0.4V, VIL = 0.8V$			- 100	μА
l <sub>l</sub>	Input curr input vo	ent at maximum oltage	$V_{CC} = MAX  V_1 = 5.5 \text{ V}$			1.0	mA
ΊΗ	High-level	input current	V <sub>CC</sub> MAX V <sub>I</sub> = 2.4V			25	μА
HL	Low-level	input current	V <sub>CC</sub> MAX V <sub>I</sub> = 0.4V			- 250	μА
los	Short-circ	uit output current	V <sub>CC</sub> = MAX V <sub>O</sub> = 0V	_ 30		- 130	mA
	Supply	16L8	V MAY	-	140	180	
lcc	Supply Current	16R4,16R6,16R8	V <sub>CC</sub> = MAX		150	180	mA

# **Recommended Operating Conditions**

Symbol	Parameter	Military			c	Unit		
		Min	Nom	Max	Min	Nom	Max	
v <sub>CC</sub>	Supply voltage	4.5	5.0	5.5	4.75	5.00	5.25	٧
ЮН	High-level output current			- 2.0			- 3.2	mA
lOL	Low-level output current			12			24	mA
TA	Operating free air temperature	- 55		125*	0		75 <sup>°</sup>	°C

<sup>\*</sup>Operating Case Temperature only, T<sub>C</sub> = 125 °C

**Switching Characteristics**Over Recommended Ranges of Temperature and V<sub>CC</sub>

Symbol	Pa	rameter	Test Conditions†† R1, R2		Military - 55° to + = 5.0V ± Typ		T <sub>A</sub> =	mmercia 0° to 7 5.0V ±	5°C	Unit
t <sub>PD</sub>	Input to output				25	45		25	35	ns
t <sub>PD</sub>	Clock to outpu	t	C <sub>L</sub> = 50pF		15	25		15	25	ns
t <sub>PZX</sub>	Pin 11 to outpu	ıt enable	]		15	25		15	25	ns
<sup>t</sup> PXZ	Pin 11 to outpu	ıt disable	CL = 5pF		15 ·	25		15	25	ns
†PZX	Input to output	enable	C <sub>L</sub> = 50pF		25	45		25	35	ns
t <sub>PXZ</sub>	Input to output	disable	C <sub>L</sub> = 5pF		25	45		25	35	ns
tw	Width of clock	High		25			25			ns
**		Low		25			25	_		
t <sub>su</sub>	Setup time	16R8,16R6,16R4		45			35			ns
-su		16X4,16A4								
th	Hold time			0	- 15		0	- 15		ns

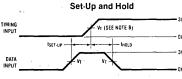
††See Standard Test Load and Definition of Waveforms

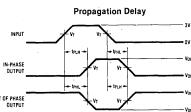
#### Standard Test Load

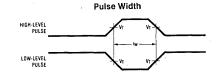


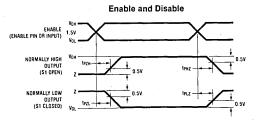
MED	PAL	SMPAL
MIL	COM, L	
R1 = 390	R1 = 200	R1 = 560
R2 = 750	R2 = 390	R2 = 1.11

#### **Test Waveforms**









Note A: C<sub>L</sub> includes probe and jig capacitance.

Note B:  $V_T = 1.5V$ .

Note C: In the examples above, the phase relationships between inputs and outputs have been chosen arbitrarily.

Note D: All input pulses are supplied by generators having the following characteristics: PRR = 1 MHz, Z<sub>OUT</sub> = 500.

# **Absolute Maximum Ratings**

	Operating	Programmi
Supply Voltage, V <sub>CC</sub>	<sup>7</sup> 7V	12V
Input Voltage	5.5 V	12 V
Off-State Output Voltage	5.5 V	12 V
Storage Temperature Range	-65°C	to +150°C

10H8A, 12H6A, 14H4A, 16H2A, 16C1A, 10L8A, 12L6A, 14L4A, 16L2A

# **Recommended Operating Conditions**

Cumbal	Parameter		Military				Commercial			
Symbol		Min.	Тур.	Max.	Min.	Typ.	Max.	Unit		
V <sub>CC</sub>	Supply Voltage	4.5	5	5.5	4.75	5	5.25	V		
Іон	High Level Output Current			-2			-3.2	mA		
lor	Low Level Output Current			12			24	mA		
TA	Operating Free-Air Temperature				0		75	°C		

# Electrical Characteristics Over Recommended Operating Temperature Range

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V <sub>IH</sub>	High Level Input Voltage		2			٧
V <sub>IL</sub>	Low Level Input Voltage				0.8	٧
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min., I <sub>I</sub> = -18mA			-1.5	٧
V <sub>OH</sub>	High Level Output Voltage	$V_{CC} = Min., V_{IH} = 2V$ $V_{IL} = 0.8V, I_{OH} = Max.$	2.4			>
V <sub>OL</sub>	Low Level Output Voltage	$V_{CC} = Min., V_{IH} = 2V$ $V_{IL} = 0.8V, I_{OL} = Max.$			0.5	>
l <sub>l</sub>	Input Current at Maximum Input Voltage	V <sub>CC</sub> = Max., V <sub>I</sub> = 5.5 V			1	mA
lн	High Level Input Current	$V_{CC} = Max., V_I = 2.4V$	1		25	μΑ
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max., V <sub>I</sub> = 0.4 V			-0.25	μΑ
los	Short Circuit Output Current	V <sub>CC</sub> = 5 V	-30		-130	mA
lcc	Supply Current	V <sub>CC</sub> = Max.	55		90	mA

Switching Characteristics Over Recommended Ranges of Temperature and  $V_{\text{CC}}$ 

Military:  $T_A = -55^{\circ}C$  to  $+125^{\circ}C$ ,  $V_{CC} = 5V \pm 10\%$ Commercial:  $T_A = 0$  to  $75^{\circ}C$ ,  $V_{CC} = 5V \pm 5\%$ 

Symbol	B	Took Conditions	Min. Typ. Max. Min. Typ. Max.					Limia	
Symbol	Parameter	Test Conditions Min. Typ. Max. Min.	Тур.	Max.	Unit				
t <sub>PD</sub>	From any Input to any Output	C <sub>L</sub> = 15pF		15	- 30		15	25	ns

# 16L8A, 16R8A, 16R6A, 16R4A, 16X4A, 16A4A

# **Recommended Operating Conditions**

0				Military	,	C	ommerc	ial	11-14
Symbol	Parai	meter	Min.	Тур.	Max.	Min.	Тур.	Max.	Unit
Vcc	Supply Voltage	,	4.5	5	5.5	4.75	5	5.25	٧
	t <sub>w</sub> Width of Clock	Low	20	10		15	10		
τ <sub>w</sub>	Wiath of Clock	High	20	10		15	10		ns
t <sub>su</sub>	Setup Time from Input or Feedback to Clock	16R8A, 16R6A, 16R4A	30	16		25	16		ns
th	Hold Time		0	-10		0	-10		ns
TA	Operating Free-Air Temperature		-55			0	25	75	°C
T <sub>C</sub>	Operating Case Temperature			125				°C	

# Electrical Characteristics Over Recommended Operating Temperature Range

Symbol	Parameter		Test Conditions		Min.	Тур.	Max.	Unit
· V <sub>IH</sub>	High Level Input Voltage			-,-	2			٧
V <sub>IL</sub>	Low Level Input Voltage						0.8	٧
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min.,	I <sub>I</sub> = -18mA			-0.8	-1.5	٧
	High Laurel Code of Valley	V <sub>CC</sub> = Min.	I <sub>OH</sub> = -2mA	MIL	0.4	0.0		
V <sub>OH</sub>	High Level Output Voltage	$V_{IL} = 0.8 V$ $V_{IH} = 2 V$	I <sub>OH</sub> = −3.2mA	СОМ	2.4	2.8		V
· · · · · · · · · · · · · · · · · · ·	Law Lawa Outant Valtana	V <sub>CC</sub> = Min.	I <sub>OL</sub> = 12mA	MIL			0.5	
, OL	Low Level Output Voltage	$V_{IL} = 0.8 V$ $V_{IH} = 2 V$	I <sub>OL</sub> = 24mA***	СОМ	7	0.3	0.5	٧
lozh	011-1-1-0-1-1-0	V <sub>CC</sub> = Max.	V <sub>O</sub> = 2.4 V				100	μΑ
lozL	Off-state Output Current	$V_{IL} = 0.8V$ $V_{IH} = 2V$	V <sub>O</sub> = 0.4 V				-100	μΑ
11	Maximum Input Current	V <sub>CC</sub> = Max.,	V <sub>I</sub> = 5.5 V				1	mA
l <sub>iH</sub>	High Level Input Current	V <sub>CC</sub> = Max.,	V <sub>I</sub> = 2.4 V				25	μΑ
I <sub>IL</sub>	Low Level Input Current	V <sub>CC</sub> = Max.,	V <sub>I</sub> = 0.4 V			-0.02	-0.25	mA
los	Output Short-Circuit Current**	V <sub>CC</sub> = 5 V	V <sub>O</sub> = 0 V		-30	-70	-130	mA
Icc	Supply Current †	V <sub>CC</sub> = Max.				120	180	mA

# Switching Characteristics Over Recommended Ranges of Temperature and V<sub>CC</sub>

Over Recommended Ranges of Temperature and  $V_{CC}$  Military:  $T_A = -55^{\circ}C$  to  $+125^{\circ}C^{*}$ ,  $V_{CC} = 5V \pm 10\%$  Commercial:  $T_A = 0$  to  $75^{\circ}C$ ,  $V_{CC} = 5V \pm 5\%$ 

Ob.a.l	B	Test Conditions††		Militar	у	C	ommer	cial	Unit
Symbol	Parameter	R1, R2	Min.	Тур.	Max.	Min.	Тур.	Max.	Unit
t <sub>PD</sub>	Input or Feedback to Output	CL = 50pF		15	30		15	25	ns
t <sub>CLK</sub>	Clock to Output or Feedback			10	20		10	15	ns
t <sub>PZX</sub>	Pin 11 to Output Enable			10	25		10	20	ns
t <sub>PXZ</sub>	Pin 11 to Output Disable	C <sub>L</sub> = 5pF		11	25		11	20	ns
t <sub>PZX</sub>	Input to Output Enable	C <sub>L</sub> = 50pF		10	30		10	25	ns
t <sub>PXZ</sub>	Input to Output Disable	C <sub>L</sub> = 5pF		13	30		13	25	ns
f <sub>MAX</sub>	Maximum Frequency		20	30		25	30		ns

 $<sup>\</sup>dagger$  I<sub>CC</sub> = Max. at minimum temperature.

<sup>††</sup>See Waveforms, Test Load on pg. 24-21.

Table 2-2.  $T_A = 25^{\circ}C$ 

Symbol	Parameter		Min	Limits Typ	Max	Units
ViĤH	Program-level input voltage		11.5	11.75	12.0	٧
		Output Program Pulse			50	
Інн	Program-level input current	OD,L/R			25	mĄ
·		All Other Inputs			5	,
Іссн	Program Supply Current			400	mA	
Тр	Program Pulse Width		10		50	μS
t <sub>d</sub>	Delay time		100			ns
	Program Pulse duty cycle				25	%
۷ <sub>P</sub>	Program/Verify-Protect-input	t voltage5.5V≤V <sub>CC</sub> ≤6V	18	18.5	19	V
lр	Program/Verify-Protect-input			400	mA	
t <sub>dv</sub>	Delay Time to Verify	100			μS	

#### **Programming**

PAL fuses are programmed using a low-voltage linear-select procedure which is common to all 15 PAL types. The array is divided into two groups, products 0 through 31 and products 32 through 63, for which pin identifications are shown in Figure 2-2. To program a particular fuse, both an input line and a product line are selected according to the following procedure:

- Raise Output Disable, OD, to V<sub>IHH</sub>.
- Select an input line by specifying I<sub>O</sub>, I<sub>1</sub>, I<sub>2</sub>, I<sub>3</sub>, I<sub>4</sub>, I<sub>5</sub>, I<sub>6</sub>, I<sub>7</sub>, and L/R as shown in Table 12.
- Select a product line by specifying A<sub>0</sub>, A<sub>1</sub>, and A<sub>2</sub> one-of-eight select as shown in Table 2-10.
- 4. Raise V<sub>CC</sub> (pin 20) to V<sub>IHH</sub>.
- Program the fuse by pulsing the output pins O<sub>n</sub> of the selected product group to V<sub>PH</sub> as shown in Table 2-4.
- 6. Lower V<sub>CC</sub> (pin 20) to 6.0 V.

- Pulse the CLOCK pin and verify output pins O<sub>n</sub> to be Low for active Low PAL types or High for active High PAL types.
- 8. Lower V<sub>CC</sub>(pin 20) to 4.5 V and repeat step 7.
- 9. Should the output not verify, repeat steps 1 through 8 up to five (5) times.

Repeat this procedure for all fuses to be blown. (See Figure 2–3.)

To prevent further verification, two last fuses may be blown by raising pin 1 and pin 11 to 18.5 volts for 10 ms–1 sec. with  $V_{CC}$  at 6.0 volts.

#### Voltage Legend

L = Low-level input voltage, VIL

H = High-level input voltage, VIH

HH = High-level program voltage, VIHH

Z = 10 k Ohms to 5.0 V.

Table 2-3. Input Line Select

Input Pin Identification Line Number 17 16 15 14 lз 12 10 L/R z нн нн ннінн 0 НН ннінн ни ни ни ни ни ни ни Z 1 Н 2 нн нн нн нн нн нн нн нн 3 нн нн нн нн нн нн н нн нн нн нн нн нн нн г 4 HH Z 5 нн нн нн нн нн нн н нн г нн нн нн нн нн нн нн нн нн 88 HA | 88 HA | 88 HA | 88 HA | 88 HA | 88 HA | 88 HA | 88 HA | 88 HA | 88 HA | 88 HA | 88 HA | 88 HA | 88 HA | 7 8 HH HH HH HH HH L нн нн z ны ны ны ны ны н HH HH Z 9 ни ни ни ни ни 10 L Інн Інні НН ни ни ни ни ни н 11 нн нн нн 12 HH HH HH HH L HH HH HH Z 13 нн нн нн нн нн [HH]HH]HH] Z 14 HH HH HH HH L |нн|нн|нн|нн HH HH HH HH HH HH HH HH 15 нн нн нн г нн нн нн нн г 16 нн нн нн н нн нн нн нн z 17 18 нн нн нн г нн нн нн нн нн HH HH HH HH HH H H HH HH 19 20 HH HH L нн нн нн нн г н |нн|нн нн нн нн нн г 21 нн 22 нн ни ни ни ни ни НН L 23 НН нн Н нн (нн (нн (нн інн інн нн|нн|нн|нн|нн| в 24 HH L 25 ни ни ни ни ни ни н н Інн 26 нн L 27 нн н 28 | HH| HH| HH| HH| HH| Z 29 | HH | HH | HH | HH | HH | Z Н

| HH | HH | HH | HH | HH | HH | HH | HH | HH | HH | HH | HH | HH

30

31

Table 2-4. Product Line Select

Product Line		F	Pin Id	entifi	catio	n .	
Number	03	02	01	00	A <sub>2</sub>	A <sub>1</sub>	A <sub>0</sub>
0,32	Z	Z	Z	НН	Z	Z	Z
1,33	Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z	Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z	Z Z Z Z Z Z	нн	Z Z Z	Z Z	нн
2,34	Z	z	Z	нн	z	нн	Z
3,35	Z	Z	Z	нн	z	нн	нн
4,36	Z	Z	Z.	нн	нн	Z Z	Z
5,37	Z	z	Z	нн	нн	Z	нн
6,38	Z	z	Z	нн	нн	нн	Z
7,39	Z	Z	Z	нн	нн	нн	нн
8,40	Z	Z	НН	Ζ	Ζ	Z	z
9,41	Z	Z	НН	Ζ	Z Z Z	Z	нн
10,42	Z	Z	НН	Z	Z	нн	z
11,43	Z	Z	нн	Z	z	НН	нн
12,44	Ž	Z	нн	Ζ	НН	Z	Z
13,45	Z	z	нн	Z	нн	z	нн
14,46	Z	Z	нн	Z	нн	нн	z
15,47	Z		нн	Z	нн	HH.	нн
16,48	Z	нн	Z	Z	Z Z Z Z	. Z	z
17,49	Z	нн	Z	Z	Z	Z	нн
18,50	Z	нн	Z	Z	Ζ	нн	z
19,51	Z	нн	Z	Z		HH.	HH
20,52	Z	нн	Ζ	Z	нн	Z Z	Z
21,53	Z	нн	·Z	Ζ	нн		НН
22,54	Z	нн	Z	Z	нн	нн	z
23,55	Z	нн	Z	Z	нн	HH	нн
24,56	нн	Z	Z	Z	Z	Ζ	z
25,57	нн	Z	Z	Z	Z	Z	НН
26,58	НН	Ζ	Z	Z	Z Z Z Z	нн	z
27,59	НН	Z Z Z Z Z Z Z	Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z	Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z		нн	нн
28,60	нн	Z	Z	Z	нн	Z	Z
29,61	нн	Z	Z	Z	нн	Z	нн
30,62	нн	Ζ	Z	Z·	нн	нн	Z
31,63	нн	Z	Z	Z	H	нн	НН

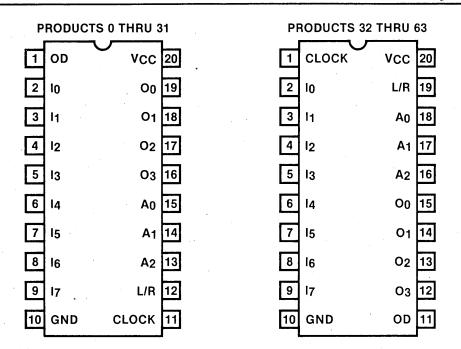


FIGURE 2-2. Pin Identification

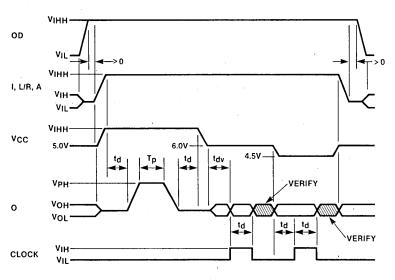


FIGURE 2-3. Programming Waveforms



# **Programmable Logic**

# Programmable Array Logic Series 24

## **General Description**

The PAL® Series 24 family compliments the PAL Series 20 family by providing two additional inputs and two additional outputs, allowing more complex functions in a single package. This new family is made feasible by the new 300 Mil-wide, 24-pin package.

In addition to providing more logic functions per chip, 24 pins allow for many natural functions which were previously unavailable in 20-pin packages. Examples include:

- · 8-bit parallel-in parallel-out counters
- 8-bit parallel-in parallel-out shift registers
- 16-Line-to-1-Line Multiplexers
- Dual 8-Line-to-1-Line Multiplexers
- Quad 4-Line-to-1-Line Multiplexers

These natural functions provide twice the density of traditional 16-pin packages.

The PAL family utilizes an advanced Schottky TTL process and the Bipolar PROM fusible link technology to provide user programmable logic for replacing conventional SSI/MSI gates and flip-flops at reduced chip count.

The family lets the systems engineer "design his own chip" by blowing fusible links to configure AND and OR gates to perform his desired logic function. Complex interconnections which previously required time-consuming layout are thus "lifted" from PC board etch and placed on silicon where they can be easily modified during prototype check-out or production. This often simplifies not only the PC board layout, but also the board itself.

The PAL transfer function is the familiar sum of products. Like the PROM, the PAL has a single array of fusible links. Unlike the PROM, the PAL is a programmable AND array driving a fixed OR array (the PROM is a fixed AND array driving a programmable OR array). In addition the PAL provides these options:

- · Variable input/output pin ratio
- Programmable three-state outputs
- · Registers with feedback

Unused inputs are tied directly to  $V_{CC}$  or GND. Product terms with all fuses blown assume the logical high state, and product terms connected to both true and complement of any single input assume the logical low state. Registers consist of D type flip-flops which are loaded on the low to high transition of the clock. PAL Logic Diagrams are shown with all fuses blown, enabling the designer use of the diagrams as coding sheets.

The entire PAL family is programmed on inexpensive conventional PROM programmers with appropriate personality cards and socket adapters. Once the PAL is programmed and verified, two additional fuses may be blown to defeat verification. This feature gives the user a proprietary circuit which is very difficult to copy.

#### **Features**

- Programmable replacement for conventional TTL logic.
- Reduces IC inventories substantially and simplifies their control.
- Reduces chip count by 5 to 1, typically.
- Expedites and simplifies prototyping and board layout.
- Saves space with 300 Mil-wide, 24-pin DIP packages.
- Programmed on standard PROM programmers.
- Programmable three-state outputs.
- Last fuse reduces possibility of copying by competitors.

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#### Table 2.5. Part Types

Part Number		Description
DMPAL12L10	DECA	12 Input AND-OR-INVERT Gate Array
DMPAL14L8	OCTAL	14 Input AND-OR-INVERT Gate Array
DMPAL16L6	HEX	16 Input AND-OR-INVERT Gate Array
DMPAL18L4	QUAD	18 input AND-OR-INVERT Gate Array
DMPAL20L10	DECA	20 Input AND-OR-Invert Gate Array
DMPAL20X10	DECA	20 Input Registered AND-OR-XOR Gate Array
DMPAL20X8	OCTAL	20 Input Registered AND-OR-XOR Gate Array
DMPAL20X4	QUAD	20 Input Registered AND-OR-XOR Gate Array
DMPAL20L2	DUAL	20 Input AND-OR-INVERT Array
DMPAL20C1	SINGLE	20 Input AND-OR-INVERT Array

# **Absolute Maximum Ratings**

Operating Programming

Supply Voltage, V<sub>CC</sub> 7V
Input Voltage 5.5V
Off-state Output Voltage 5.5V
Storage Temperature

12V\* 12V -65°C to +150°C

12V

# **Operating Conditions**

Combal	Dovonielo	·	Military		. C	ommerc	ial	11-24
Symbol	Parameter	Min.	Тур.	Max.	Min.	Тур.	Max.	Unit
Vcc	Supply Voltage	4.5	5	5.5	4.75	5	5.25	٧
TA	Operating Free-air Temperature			-	0		75	ů
T <sub>C</sub>	Operating Case Temperature	-55		125				°C

# **Electrical Characteristics** Over Operating Conditions

Symbol	Parameter		<b>Test Conditions</b>		Min.	Тур.	Max.	Unit
V <sub>IL</sub>	Low Level Input Voltage						.0.8	٧
V <sub>IH</sub>	High Level Input Voltage				2			V
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> = Min.	I <sub>I</sub> = -18mA				-1.5	V
I <sub>IL</sub>	Low Level Input Current †	V <sub>CC</sub> = Max.	V <sub>I</sub> = 0.4V				-0.25	mA
I <sub>IH</sub>	High Level Input Current †	V <sub>CC</sub> = Max.	V <sub>I</sub> = 2.4V				25	μΑ
11	Maximum Input Current	V <sub>CC</sub> = Max.	V <sub>I</sub> = 5.5V				1	mΑ
VoL	Low Level Output Voltage	$V_{CC} = Min.$ $V_{II} = 0.8V$	I <sub>OL</sub> = 12 mA	MIL			0.5	. v
VOL	Low Level Output Voltage	$V_{IH} = 0.8V$	I <sub>OL</sub> = 24 mA	сом			0.5	<b>'</b>
VoH	High Level Output Voltage	$V_{CC} = Min.$ $V_{II} = 0.8V$	I <sub>OH</sub> = −2 mA	MIL	2.4			v
•он	riigii Levei Output voitage	$V_{IH} = 0.8V$ $V_{IH} = 2V$	I <sub>OH</sub> = -3.2mA	сом	2.4			\ \ \
l <sub>ozL</sub>	Off-state Output Current †	$V_{CC} = Max.$ $V_{II} = 0.8V$	V <sub>O</sub> = 0.4V				-100	μΑ
lozh	On-state Output Current 1	$V_{1H} = 0.8V$	V <sub>O</sub> = 2.4V				100	μΑ
los	Output Short-Circuit Current**	V <sub>CC</sub> = Max.	V <sub>O</sub> = 0V		-30		-130	mΑ
Icc	Supply Current	V <sub>CC</sub> = Max.	20X4, 20X8, 20	)X10		120	180	mA
100	Cappiy Carrent	VCC - Max.	20L10			90	165	'''^

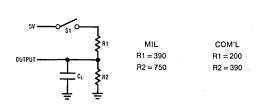
I/O pin leakage is the worst case of I<sub>OZX</sub> or I<sub>IX</sub>, e.g. I<sub>IL</sub> and I<sub>OZH</sub>. Pins 1 and 13 may be raised to 22V max.

\* Only one output shorted at a time.

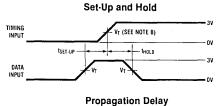
# Switching Characteristics Over Operating Conditions

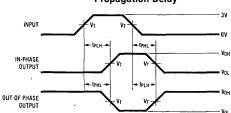
Symbol	D.	rameter	Test Conditions	Conditions Military Commercial		ial	Unit			
Syllibol	Fa	ranietei	R1, R2	Min.	Тур.	Max.	Min.	Тур.	Max.	Onit
t <sub>PD</sub>	Input or Feedba	ack to Output	20L10, 20X10 20X8, 20X4 C <sub>L</sub> =50 pF		35	60		35	50	ns
t <sub>PD</sub>	Input or Feedback to Output		12L10, 14L8, 16L6 18L4, 20L2, 20C1 C <sub>L</sub> = 50 pF		25	45		25	40	ns
t <sub>CLK</sub>	Clock to Output or Feedback		C <sub>L</sub> = 50 pF		20	40		20	30	ns
t <sub>PZX</sub>	Pin 13 to Output Enable		C <sub>L</sub> = 50 pF		20	45		20	35	ns
t <sub>PXZ</sub>	Pin 13 to Output Disable		C <sub>L</sub> = 5 pF		20	45		20	35	ns
t <sub>PZX</sub>	Input to Output	Enable	$C_L = 50 pF$		35	55		35	45	ns
t <sub>PXZ</sub>	Input to Output	Disable	$C_L = 5 pF$		35	55		35	45	ns
	Width of Clock	Low		30			25			ns
.t <sub>W</sub>	Width of Clock	High		40			35			ns
t <sub>SU</sub>	Set-Up Time fro	Set-Up Time from Input or Feedback		60			50			ns
t <sub>h</sub>	Hold Time	Hold Time		0	- 15		0	15		ns
f <sub>MAX</sub>	Maximum Freq	uency		10.0			12.5			MHz

#### **Test Load**



# **Test Waveforms**





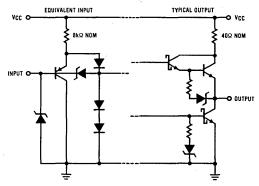
Note A:  $C_L$  includes probe and jig capacitance.

**Note B:**  $V_T = 1.5V$ .

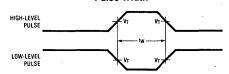
Note C: In the examples above, the phase relationships between inputs and outputs have been chosen arbitrarily.

Note D: All input pulses are supplied by generators having the following characteristics: PRR = 1 MHz, Z<sub>OUT</sub> = 50Ω.

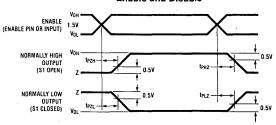
# **Schematic of Inputs and Outputs**



#### Pulse Width



#### **Enable and Disable**



#### **Programming**

PAL fuses are programmed using a low-voltage linearselect procedure which is common to all PAL types. The array is divided into two groups, products 0 thru 39 and products 40 thru 79, for which pin identifications are shown in Pin Configurations below. To program a particular fuse, both an input line and a product line are selected according to the following procedure:

- Step 1 Raise Output Disable, OD, to VIHH.
- Step 2 Select an input line by specifying  $l_0$ ,  $l_1$ ,  $l_2$ ,  $l_3$ ,  $l_4$ ,  $l_5$ ,  $l_6$ ,  $l_7$ ,  $l_8$ ,  $l_9$  and L/R as shown in Table 2-6.
- Step 3 Select a product line by specifying  $A_0$  and  $A_1$  one-of-four select as shown in Table 2-7.
- Step 4 Raise V<sub>CC</sub> (pin 24) to V<sub>IHH</sub>.
- Step 5 Program the fuse by pulsing the output pins, O, of the selected product group to  $V_{IHH}$  as shown in Programming Waveform.

- Step 6 Lower V<sub>CC</sub> (pin 24) to 6.0 V.
- Step 7 Pulse the CLOCK pin and verify the output pin, O, to be Low for active Low PAL types or High for active High PAL types.
- Step 8 Lower V<sub>CC</sub> (pin 24) to 4.5 V and repeat Step 7.
- Step 9 Should the output not verify, repeat steps 1 thru 8 up to five (5) times.

This procedure is repeated for all fuses to be blown (see Programming Waveforms).

To prevent further verification, two last fuses may be blown by raising pin 1 and pin 13 to 18.5 volts with  $V_{CC}$  at 6.0 volts

## Voltage Legend

L = Low Level Input Voltage, V<sub>IL</sub> H = High Level Input Voltage, V<sub>IH</sub> HH = High Level Program Voltage,  $V_{IHH}$  Z = High Impedance (e.g. 10k Ω to 5.0V)

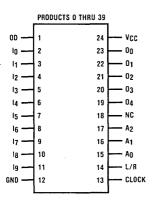
Table 2-6. Input Line Select

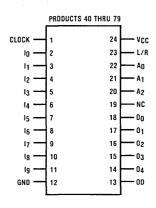
	lable 2-6. Input Line Select										
Input Line				Pi	n Ide	entifi	cati	on			
Number	lg	I <sub>8</sub>	17	16	I <sub>5</sub>	I <sub>4</sub>	13.	l <sub>2</sub>	l <sub>1</sub>	l <sub>o</sub>	L/R
0	нн	нн	НН	НН	нн	нн	нн	нн	нн	L	Z
1	нн	нн	нн	нн	нн	нн	нн	НН	нн	Н	Z
2	НН	ΗН	ΗН	НН	нн	НН	нн	НН	нн	L	HH
3	НН	нн	нн	ΗН	ΗН	нн	нн	нн	нн	Н	HH
4	НН	нн	нн	нн	нн	нн	HH	НН	L	нн	Z
5	НН	ĤΗ	ΗН	НН	ΗН	ΗН	ΗН	НН	Н	НН	Z
6	HH	НН	НН	ΗН	ΗН	ΗН	нн	ΗН	L	нн	HH
7	HH	ΗН	нн	НН	ΗН	ΗН	ΗН	ΗН	Н	ΗН	HH
8	HH	нн	НН	ΗН	ΗН	ΗН	нн	L	НН	нн	Z
9	нн	ΗН	ΗН	НН	НН	ΗН	ΗН	Н	ΗН	ΗН	Z
10	нн	HH	HH	ΗН	ΗН	ΗН	ΗН	L	ΗН	нн	HH
11	нн	нн	нн	НН	нн	нн	нн	Н	нн	нн	НН
12	HH	НН	ΗН	НН	НН	нн	L	НН	нн	ΗН	Z
13	нн	нн	НН	НН	ΗH	ΗН	Н	НН	ΗН	нн	Z
14	HH	ΗН	нн	нн	ΗН	нн	L	НН	нн	нн	HH
15	нн	НН	нн	НН	нн	нн	Н	нн	НН	нн	НН
16	нн	нн	нн	НН	нн	L	ΗН	ΗН	нн	ΗН	Z
17	HH	НН	ΗН	ΗН	НН	Н	НН	НН	нн	ΗН	Z
18	нн	нн	НН	НН	НН	L	нн	нн	нн	нн	НН
19	HH	НН	ΗН	НН	нн	Н	ΗН	НН	нн	ΗН	HH
20	HH	ΗН	нн	НН	L	ΗН	ΗН	ΗН	нн	НН	Z
21	нн	ΗН	нн	НН	Н	НН	нн	ΗН	нн	нн	Z
22	нн	ΗН	НН	НН	L	ΗН	HH	НН	нн	ΗН	HH
23	HH	нн	HH	HH	Н	НН	ΗН	ΗН	ΗН	НН	НН
24	HH	ΗН	НН	·L	ΗН	ΗН	ΗН	НН	нн	ΗН	Z
. 25	нн	нн	НН	H	ΗН	ΗН	ΗН	ΗН	нн	нн	Z
26	HH	НН	нн	L	НН	НН	НН	НН	ΗН	нн	HH
27	HH	нн	ΗН	·Н	НН	НН	нн	НН	нн	HH	HH
28	НН	НН	L	нн	нн	НН	НН	ΗН	нн	нн	Z
29	нн	нн	Н	НН	нн	НН	НН	ΗН	нн	нн	Z
30	нн	НН	L	НН	нн	НН	НН	ΗН	нн	нн	НН
31	нн	HH	Н	НН	нн	ΗН	нн	НН	нн	нн	HH
32	нн	L	HH,	НН	ΗН	нн	нн	ΗН	нн	ΗН	Z
33	НН	Н	НН	НН	нн	нн	нн	ΗН	НН	нн	Z
34	нн	L	нн	НН	нн	HH	нн	НН	ΉН	нн	НН
35	НН	Н	нн	нн	нн	ΗH	НН	нн	нн	НН	нн
36	L	нн	нн	НН	НН	нн	нн	НН	нн	НН	Z .
37	Н	нн	НН	НН	НН	нн	нн	НН	нн	нн	Z
38	L	нн	НН	НН	ΗH	нн	нн	нн	нн	нн	нн
39	Н	НН	нн	НН	ΗĦ	нн	нн	нн	нн	нн	нн

Table 2-7. Product Line Select

Product Line			Pin	Iden	tificat	ion		
Number	04	O <sub>3</sub>	02	01	00	A <sub>2</sub>	A <sub>1</sub>	A <sub>0</sub>
0, 40	Z	Z	Z	Z	нн	Z	Z	Z
1, 41	z	Z	Z	Z	HH	Z	Z	нн
2, 42	Z	Z	Z.	Z	нн	Z	нн	Z
3, 43	z	Z	Z	Z	HH	Z	нн	HH
8, 48	Z	Z	Z	НН	Z	Z	Z	Z
9, 49	z	Z	Z	HH	Z	Z	Z	НН
10, 50	Z	Z	Z	НН	Ζ.	Ζ.	нн	Z
11, 51	Z	Z	Z	HH	Z	Z	HH	нн
16, 56	Z	Z	HH	Z	Z	Z	Z	Z
17, 57	Z	Z	HH	Z	Z	Z	Z	нн
18, 58	Z	Z	ΗН	Z	Z	Z	нн	Z
19, 59	Z	Z	ΗН	Z	Z	Z	ΗН	нн
24, 64	z	HH	Z	Z	Z	Z	Z	Z
25, 65	Z	ΗН	Z	Z	Z	Z	Z	нн
26, 66	Z	ΗН	Z	Z	Z	Z	НН	Z
27, 67	Z	ΗH	Z	Z	Z	Z	нн	нн
32, 72	HH	Z	Z	Z	Z	Z	Z	Z
33, 73	нн	Z	Z	Z	Z	Z	Z	ΗH
34, 74	нн	Z	Z	Z	Z	Z	нн	Z
35, 75	НН	Z	Z	Z	Z	Z	HH	нн
36, 76	НН	Z	Z	Z	Z	нн	Z	Z
37, 77	HH	Z	Z	Z	Z	HH	Z	нн
38, 78	нн	Z	Z	Z	Z	·HH	нн	Z
39, 79	нн	Z	Z	Z	Z	НН	нн	нн

# **Pin Configurations**

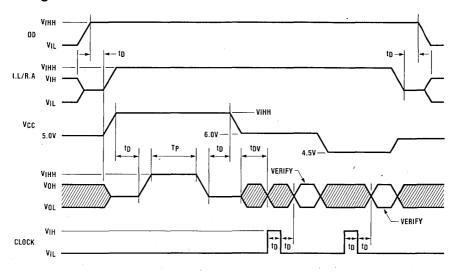




# Programming Parameters $T_A = 25$ °C

C	Donomoto.	_				
Symbol	Paramete	r	Min.	Тур.	Max.	Unit
VIHH	Program-level Input Voltage		11.5	11.75	12.0	V
		Output Program Pulse			50	
hнң	Program-level Input Current	OD, L/R	<u> </u>	50		mA
		All Other Inputs			5	
Іссн	Program Supply Current				400	mA
T <sub>P</sub>	Program Pulse Width		10		50	μS
t <sub>D</sub>	Delay Time		100			. ns
t <sub>DV</sub>	Delay Time to Verify		100			μS
	Program Pulse Duty Cycle				25	%
V <sub>P</sub>	Verify-Protect Input Voltage 5.5	V≤V <sub>CC</sub> ≤6.0V	18.	18.5	19	٧
lр	Verify-Protect Input Current				400	mA
T <sub>PP</sub>	Verify-Protect Pulse Width		20		50	ms

# **Programming Waveforms**





# **Programmable Logic**

## PAL Design Selecting the Right PAL

PAL part types come in small, medium, and large sizes, offering a wide range of complexities. The small PALs are also referred to as combinational because they just do logic functions. Four of these small PALs have active-high outputs (the "H" series), and four have active-low outputs (the "L" series), with a variety of input/output pin ratios. The one small PAL left over is the 16C1, which has complementary outputs. The small PAL types can replace random SSI gate functions at about a 4-to-1 chip-count reduction. This group is designed to provide low-power Schottky (LS) fan-out and fan-in characteristics of 8 mA output sink (IOI) for totem-pole outputs and 0.25 mA input loading (III).

The simplest medium PAL, the 16L8, is logically the same as the 10L8, with six added inputs that are shared with output pins. The 16 in its type number thus refers to the number of input variables to its AND matrix. Its unique logic is shown in Figure 3-2. Its TRI-STATE® outputs are controlled by lines from the AND matrix, so can be acted upon by input variables. These pins therefore serve as I/O in a bus-oriented environment.

Other medium PALs are the R (Register) devices. Figure 3-3 is a simplified diagram showing the logic embodied in the R series. The unique feature of the Register PAL is the D-type register element following each OR gate. A common clock input latches data into all register elements simultaneously on the rising edge of the clock pulse. The register outputs are connected to TRI-STATE buffers, controlled by a common enable input.

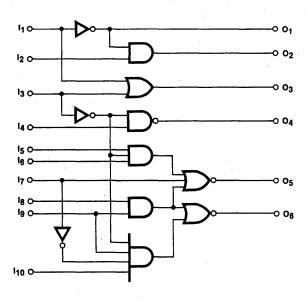


FIGURE 3-1. Typical Combinational Logic Application.

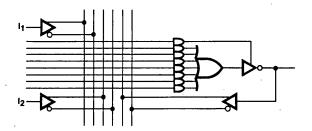


FIGURE 3-2. Simplified Logic Diagram of the 16L8 PAL®

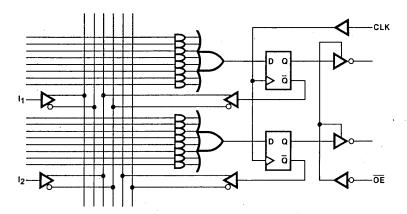


FIGURE 3-3. Logic of the R Series PAL®

A significant feature of the register PALs is the register feedback path to the AND matrix. This feedback path allows the PALs to be used in state-machine applications in which the feedback loops are all on-chip. These devices are especially useful in the design of custom registers, shifters, and counters.

The three register PALs are the 16R8, 16R6, and 16R4, which have eight, six, and four register elements, respectively. Each has eight outputs; those not serving the register elements are of the I/O variety, like those on the 16L8, above. Their outputs are bus drivers that will deliver the standard LS output sink of 24 mA ( $I_{OI}$ ).

Two members of the PAL family (16x4 and 16A4) are referred to as large PALs. These two devices facilitate the arithmetic functions, add, subtract, greater than, and less than, by means

of the two additional features shown in Figure 3-4. The sum of the products (OR outputs) is segmented into two, which are then XOR'd to the D flip-flop input. This allows carries from previous operations to be XOR'd with the two variable sums generated by the AND array.

A second feature is the gating of the register feedback path and inputs, forming the terms I+Q, I+/Q, II+Q, and II+/Q. This provides versatile operations on two variables and facilitates the parallel generation of carries. These two parts also have bus-driver outputs. You can expect "compression ratios" (package count reductions) of up to 12:1 by comparison with existing combinations of MSI and discretes. You can also invent new and unique LSI functions with these parts, and implement them without having to spend huge sums on masks or tooling.

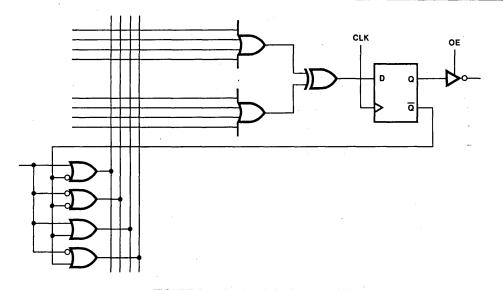


FIGURE 3-4. Logic of the Large PAL®

**Designing the PAL** Once a particular PAL device is selected, it is time to generate the PAL design. This can be done either manually or through the use of a software tool called PALASM<sup>TM</sup>, described on page 24-41.

The coding conventions adopted to describe PAL programming are described in Figure 3-20. The arbitrary circuit of Figure 3-21 is used as a design example for selecting and

coding a PAL. Since no registers are called for, the device to implement this function may be selected from among the H, L, and C types. Since the lower part of the diagram displays AND-OR-INVERT functions, the L series is most likely.

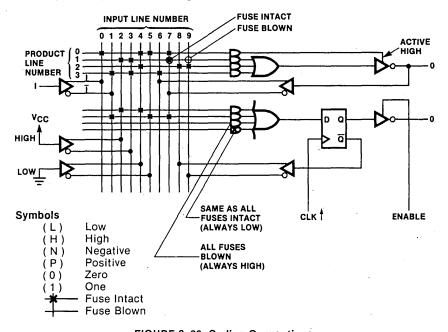


FIGURE 3-20. Coding Conventions.

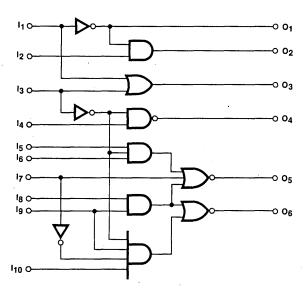


FIGURE 3-21. Design Example, Logic Diagram.

The next step: the number of inputs (10) and the number of outputs (6) indicates that a 10L8, 12L6, or 16LB could accommodate the entire circuit. Since the 10L8 and 12L6 are "small" PALs and hence less costly than the 16L8 "medium" device, the choice should be made between these two if possible. A review of the 10L8's logic diagram shows that all of its NOR gates are two-input gates, and the design example requires a three-input gate. On the other hand, the 12L6 has two 4-input gates which will accommodate the three-input requirement. It, therefore, is selected. Having chosen an inverting type of PAL, you apply DeMorgan's theorem to handle the inversion at the NOR gates feeding all of its outputs. Demorgan's theorem can be used to convert any logic form to the AND-OR/AND-NOR PAL format. This has been done in the equations below; the PAL AND-NOR format shown on the right.

$$O_{1} = II_{1} \qquad \cong \qquad IO_{1} = I_{1}(1)$$

$$O_{2} = II_{1} \bullet I_{2} \qquad \cong \qquad IO_{2} = I_{1} + II_{2}(2)$$

$$O_{3} = I_{1} + I_{3} \qquad \cong \qquad IO_{3} = II_{1} \bullet II_{3}(3)$$

$$O_{4} = I(II_{3} \bullet I_{4}) \qquad \cong \qquad IO_{4} = II_{3} \bullet I_{4}(4)$$

$$O_{5} = I(II_{3} \bullet I_{5} \bullet I_{6} + I_{7} + I_{8} \bullet I_{9})$$

$$\cong \qquad IO_{5} = II_{3} \bullet I_{5} \bullet I_{6} + I_{7} + I_{8} \bullet I_{9}(5)$$

$$O_6 = /(I_8 \bullet I_a + /I_3 \bullet /I_7 \bullet I_9 \bullet I_{10})$$

$$= /O_6 = I_8 \bullet I_9 + /I_3 \bullet /I_7 \bullet I_9 \bullet I_{10} (6)$$

Assuming that there are no board layout constraints, input  $I_1$  through  $I_{10}$  may be assigned to pins 1 through 11. (Pin 10 is ground.) The only constraint on output pin assignment is that  $O_5$  must be assigned to pin 13 or 18 to take advantage of one of the 4-input NOR gates.

O<sub>1</sub> is assigned to pin 18. To make this output the inverse of I<sub>1</sub>, leave input line 2 connected (not blown) to product line 8 and blow all the remaining fuses on that product line. This is indicated by the X on the intersection of input line 2 and product line 8 in Figure 3-24.

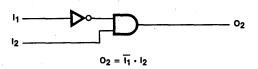


FIGURE 3-22. The Logic Diagram and Expression for Output 2.

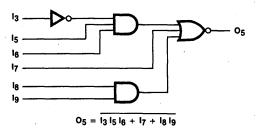


FIGURE 3-23. The Logic Diagram and Expression for Output 5.

As the other three inputs to NOR gate 1 are not used, they are forced to zero by leaving all fuses intact on product lines 9,10, and 11. (As shown in Figure 3-20, instead of confusing the diagram with many Xs, the unused inputs are indicated by Xs in the small AND symbols at the NOR gate inputs.)

The next output,  $O_2$ , is the AND function of  $II_1$  and  $II_2$  (Figure 3-22). In the L series, the AND gates cannot be brought to outputs without inversion, but by DeMorgan's theorem, the equivalent function can be constructed by taking the complements of the two inputs, ORing them, and inverting the result. Equation (2), on Page 24-36 shows the form that can be coded directly into the 12L6. The coding of this expression, using pin 1 and the complement of pin 2 as inputs 1 and 2, respectively, and pin 17 as output 2, is marked with Xs on product lines 1 and 2 in Figure 3-24.

Output  $O_3$  is the OR of  $I_1$  and  $I_3$ . Again, the output inversion of the L series suggests the double-inversion application of DeMorgan's theorem, as shown in Equation (3). To do this, connect input lines 3 ( $I_1$ ) and 5 ( $I_3$ ) to product line 24. Since no other input is needed to NOR gate 3, its other input is forced low by leaving all its fuses intact. The X at the unused gate input shows this on the diagram.

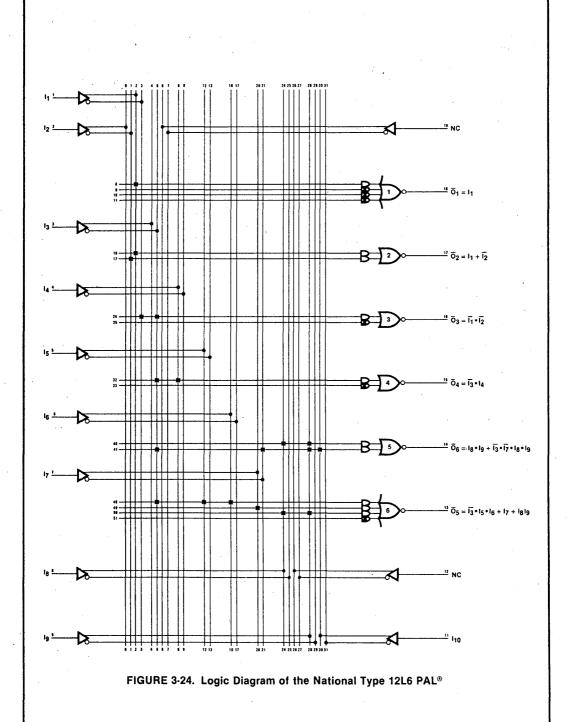
Output  $O_4$  is the NAND function of  $II_3$  and  $I_4$ . This is accomplished by ANDing input line 5 ( $II_3$ ) and input line 8 ( $I_4$ ) on product line 32, which produces  $I(II_3 \bullet I_4)$  at the output of NOR gate 4, with its unused input tied to 0 (all fuses intact)

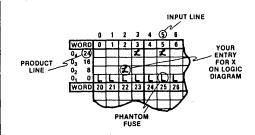
Output  $O_5$  is generated by ANDing  $I_3$ ,  $I_5$ , and  $I_6$  on product line 48, ANDing  $I_8$  and  $I_9$  on line 50, connecting  $I_7$  to product line 49, and leaving unused line 51 grounded. (See Figures 3-23 and 3-24.)

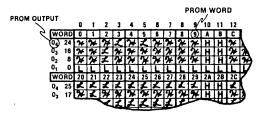
Output  $O_6$  is generated by ANDing  $I_8$  and  $I_9$  on product line 40 and  $II_3$ ,  $II_7$ , Ig, and  $I_{10}$  on product line 41, which, inverted by NOR gate 5, results in  $IO_6$ . [See Equation (6).]

The coding for a completed PAL design must be transformed into a format more readily interpreted for execution on commercially available PROM programming devices. A form for doing this is shown in Figure 3-25. The numbers along the top of the figure correspond with the input line numbers that appear across the top of the logic diagram (Figure 3-24). The product term line numbers along the left side of these two illustrations correspond also.

Note that some of the boxes in Figure 3-25 are filled in with Gothic L's. These represent phantom fuses, which are fuse locations not accessible in the given device type but which must be accounted for to provide the programmer with the proper data for verification. For the present, these entries can be ignored. To fill in the remaining boxes, begin with the first X marked on the logic diagram, Figure 3-24. It is located at the intersection of input line 2 and product term 8. Since this is an intact fuse, an L (for Low) is entered in the corresponding box of Figure 3-25, as detailed below.







#### NOTE

Script L's (4) are used to differentiate entries being programmed and entries already on the form. In practice, this is not necessary.

Next L's are entered in all of the blank spaces for product term 9 on the form (Fig. 3-25), since this is an unused line, as indicated by the X at the input to the NOR gate for this product term on the logic diagram. Similarly, complete lines of L's are entered for product terms 10 and 11. Every X on the logic diagram must be entered on the PAL programming form as an L or, in the case of the unused gate inputs, as a row of L's. Figure 3-25 is shown with all the necessary L's filled in.

Since all of the remaining fuses are to be blown, H's must be written into the remaining blanks. For clarity, this is not done in Figure 3-25, but a portion of the completed programming format is shown below.

Once the programming format is complete, the input line and product term numbers can be forgotten. What the format sheet does is translate these into their equivalent hexadecimal input words and outputs, in the form

acceptable by a device that programs 512 x 4 PROMs. Thus, to program the example currently under discussion, insert the 12L6 PAL into the socket of a suitably configured programmer and enter the following:

Word	Output
No.	04 03 02 0
0 1 2 3 4 5 6	H H H L H H H L L H H L L H H L H H H L
1F 20 21 22	H H H L L H L L L H L L
1FF	LLLL

After the PAL is programmed and verified, it must be tested logically in the PAL mode to eliminate defects which cannot be tested at the factory prior to programming.

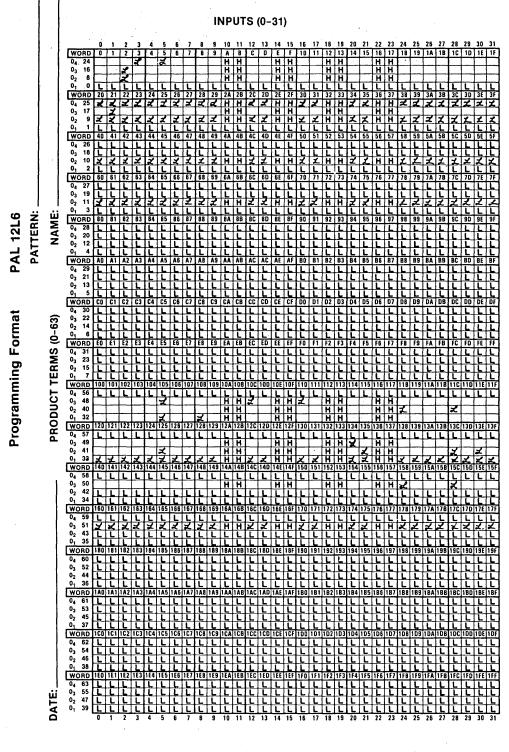


FIGURE 3-25. Programming Format Sheet for National Type 12L6 PAL. TM

Executing this sequence programs a Type 12L6 PAL to implement the logic function shown in Figure 3–21. Programming format sheets and logic diagrams that show all fuse locations for all 15 of the PAL devices are shown later in this section.

#### Phantom Fuses

Phantom fuse locations are those locations where a fuse does not exist. These are revealed as missing outputs, missing product terms, or missing input lines in the logic diagrams, Figures 3–5 through 3–19. PALs with phantom fuse locations appear the same to the programming device as partially programmed 512 x 4 PROMs. As the programmer expects to verify all 2048 locations, the PAL programming format must provide the expected pattern for verifying nonexistent fuse nodes. When filling out the programming format, refer to Figure 3–26, the key to phantom fuse locations in the complete logic schematics that follow.

#### PALASM TM

Manual PAL coding, while practical for one or two designs, is far too tedious and error-prone for continual use. What is needed is a computer-aided design technique that automates the design process to the highest degree possible. One such design aid is a FORTRAN-IV-based software package called PALASM. This design aid allows PALs to be

designed by writing logic equations to represent the desired logic function. The output of PALASM is a programming tape that can be used as a data input by most PROM programmers that have PAL personality cards. Its output format can be BHLF, BPNF, or Hexadecimal.

The simplest way to describe PALASM is with a design example. The same arbitrary sample function that is described on the previous pages is "designed" using PALASM in the discussion that follows. The logic diagram is shown in Figure 3–21. Figure 3–27 shows the logic operators recognized by the assembler. Figure 3–28 is the input to PALASM that is compiled by the program and generates the code for the programming device.

- = Equal
- := Replaced by, following clock
- / Complement
- \* AND, PRODUCT
- + OR, SUM
- +: XOR
- :★: XNOR
- () Conditional TRI-STATE IF statement, arithmetic

FIGURE 3-27. PALASM Operators

	Active I	ligh Logic	Active Low Logic			
	(PAL 10H8, 12 14H4, 16	H6, LEGEND H2)	(PAL 10L8, 12L6, LEGEND 14L4, 16L2)			
1) Missing Output	H (P,1)	ф	L (N,O)	- <b>ợ</b> -		
2) Missing product	L (N,O)	- <b>ọ</b> -	L (N,O)	-φ-		
3) Missing input lines	H (P,1)	ф	H (P,1)	- <b></b> -		

Note 1: Missing product term overrides missing input line.

Note 2: For PAL 16C1, first half of the array (product terms 0·31) acts as active high logic and the second half of the array (product terms 32·63) acts as active low logic device.

FIGURE 3-26. PAL Phantom Fuse Symbology.

The PALASM program is instructed to generate code with which to program the 12L6 by keying the sequence shown in Figure 3-28 into its host computer as follows:

Line 1: At the left margin, the PAL device is specified. For this example, the 12L6 remains the best solution. "PAL DESIGN SPECIFICATION" is entered at the right.

Line 2: A unique pattern number for this PAL design is entered at the left margin on line 2, followed by designer's name and date.

Line 3: The name or description of the device or function is entered. If this runs over one line, Line 4 may be used to complete it.

**Line 4:** If not used to complete line 3, this line is skipped.

Line 5, 6, and 7: These lines are used for pin assignments. All 20 of the pins on the PAL are assigned symbolic names, usually corresponding to the symbols used on the logic diagram. (Note that GND and  $V_{\rm CC}$  must be included.) Assignment starts at pin 1 and proceeds sequentially, through pin 20. (See Figure 3-24 for sample pinouts.)

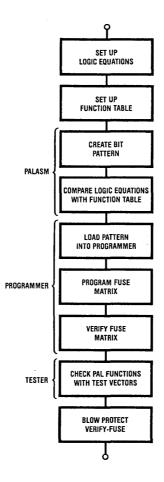
```
Line 1
           PAL 12L6
                         PAL Design Specification
Line 2
           PAT 1476
                         Bob Jones 5/10/81
Line 3
           PAL Design Example
Line 4
Line 5
           11 12 13 14 15 16 17 18 19 GND 110 NC O5
           06 04 0302 01 NC Vcc
Line 6
Line 7
          10_1 = 1_1
Line 8
          10_2 = 1_1 + 11_2
Line 9
Line 10
          10_3 = 11_1 * 11_3
          10_4 = 11_3 * 1_4
Line 11
          10_6 = 1_8 * 1_9 + 1_9 + 1_3 * 1_7 * 1_9 * 1_{10}
Line 12
Line 13
          0_5 = 1_3 * 1_5 * 1_6 + 1_7 + 1_8 * 1_9
Line 14
Line 15
           Description
Line 16
Line 17
           This program is a design example describing
Line 18
           the use of PALASM as a PAL design aid.
```

An additional design example using PALASM is shown on page 24-46. This is followed by the complete PALASM listing.

FIGURE 3-28. Example of PALASM (TM) Program Input

#### **PAL Programming Procedure**

The entire procedure for programming a PAL is shown in the block diagram below. The first step is to generate the logic equations and function table and then, using PALASM, to create bit pattern and compare logic equations with the function table. The third step is to load the bit pattern into a PAL programmer\* to program and verify the fuse matrix. The fourth step is functionally testing the PAL with test vectors on a functional tester. The last step, blowing the protect verify fuse, is optional.



<sup>\*</sup>See next page for details of PAL programmers.

# **PAL Programmers**

Manufacturer	Basic Equipment	PAL-Modul	Adapters	PAL Design-	Performs	Storage F	Prog	rams	Blows		
* .				Software Included	Logic Simulation	Bit Pattern	Test Vectors	20- Pin	24- Pin	Security Fuses	
Data I/O	Model 17, 19, 29A or 100A	1427	1428-1 -2 -3	no	no	Master PAL		yes	no	no	
Digelec	μP 803	FAM 51	20 + 24 pin socket	yes	no	Master PAL	-	yes	yes	yes	
Kontron	EPP 80 or MPP 80S	MOD 21	SA 27 + SA 27 - 1	no	no	Master PAL		yes	yes	yes	
Prolog	Progr. 910 or PM906 980 or NSC Starplex <sup>TM</sup>		S 1 2 3	no	no	Master PAL	_	yes	no	yes	
Stag	PPX	PM 202 + BRAL	AM10H8 • • • • • • • • • • • • • • • • • • •	yes	no	Master PAL	_	yes	no	yes	

All these systems program and verify the PALs in the PROM mode, they do not perform a logic simulation in the PAL mode 1. Additional (external) circuitry for logic simulation should be used if PALs go into volume production—otherwise a small percentage of the PALs will show failures when testing the complete PC board! OK for prototype-making.

## **PAL Development Systems**

Manufacturer	Basic Equipment	PAL-Modul	Adapters	PAL Design-	Performs	Storage N	Media for		rams	Blows
_				Software Included	Logic Simulation	Bit Pattern	Test Vectors	20- Pin	24- Pin	Security Fuses
Data I/O	Model 17, 19, 29A or 100 and any terminal	Logic-Pack	Design ad. and Progr. ad	yes	Yes, automatic or manual generation of test vectors	Master PAL	external	yes	yes	yes
Digelec	μP 803	FAM 52	20 and 24- pin adapter	yes	Yes, automatic or manual generation of test vectors	Master PAL	external	yes	yes	yes
Stag	7	ZL 30		yes	Yes, automatic or manual generation of test vectors	Master PAL	external	yes	yes	yes
Structured Design	any terminal	SD20/24	_	yes	Yes, manual generation of test vectors	Master PAL or on waf	external or internal ertape	yes	yes	no

All these systems allow software supported PAL design. They perform a fuse-verify in the PROM mode and can do a logic simulation in the PAL mode!

All 5 programmers and 4 development systems can be connected with a host computer to run more sophisticated design software and/or for storage use.

#### **PAL Legend**

#### **Constants**

LOW (L) NEGATIVE (N) ZERO (0) GND FALSE  $\times$  FUSE NOT BLOWN HIGH (H) POSITIVE (P) ONE (1)  $V_{CC}$  TRUE - FUSE BLOWN

#### **Operators**

- = EOUAL
- := REPLACED BY FOLLOWING CLOCK
- / COMPLEMENT
- \* AND, PRODUCT
- + OR, SUM
- :+: XOR
- :\*: XNOR
- ( ) CONDITIONAL THREE STATE, IF STATEMENT, ARITHMETIC

#### **Equations**

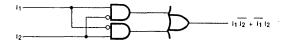
Standard

 $Q_1 = I_1 \overline{I_2} + \overline{I_1} I_2$ 

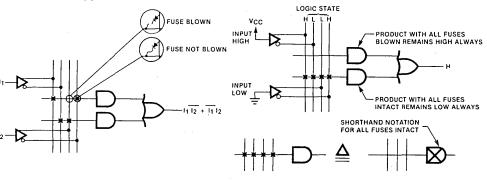
PALASM

01 = I1\*/I2 + /I1\*I2

### **Conventional Symbology**



#### **PAL Symbology**



### **PAL Logic Diagram**

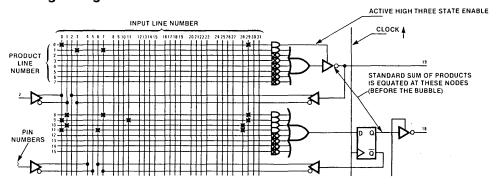
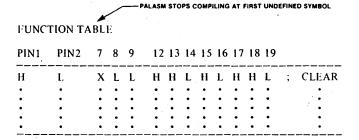


FIGURE 3-29. PAL Legend

# Sample PAL Design Specification PAL PART NO. (MUST START AT LINE 1, COLUMN 1) PATTERN NO. NAME OF DEVICE (MUST START ON LINE 3) PALXXXX PAL DESIGN SPECIFICATION PATXXXX AUTHOR'S NAME, DATE NAME OF DEVICE (EG. CLOCK GENERATOR, PORT ADDRESS DECODER, ETC.) PIN1 PIN2 3 /4 5 6 7 8 9 GND 11 12 13 /14 15 16 /17 18 19 VCC PIN LIST (MUST START ON LINE 5) CONSISTS OF 20 SYMBOLIC NAMES WHICH ARE CONSECUTIVELY ASSIGNED TO PINS 1 THRU 20. 19 = PIN1\*4 + /PIN218 = 5 + 6 + 7 + /8 + 9\*11/17 := 8\*9 16 = 9\*8EQUATIONS IF (PIN1\*PIN2) 15 = 3 + 6/14 = 3 + 6



IF (VCC) 13 = 8\*7 + PIN2

CONDITIONAL THREE STATE

FIGURE 3-30. Sample PAL Design Specification.

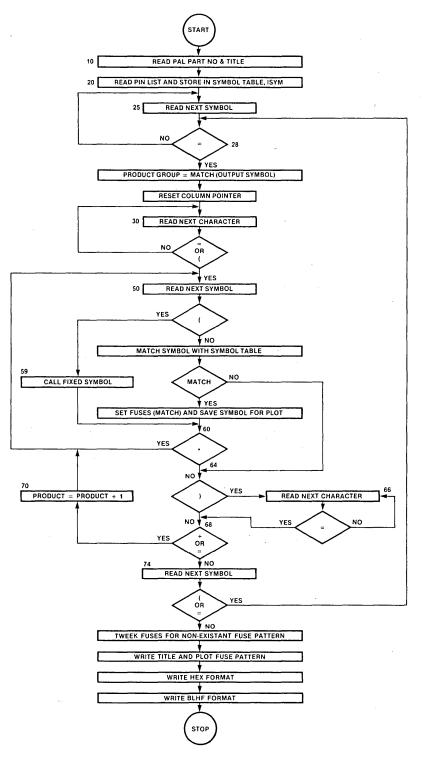


FIGURE 3-31. PALASM<sup>TM</sup> Flow Chart.

# Listing 1. PALASM Source Code for 20 Series

FILE: PALZO FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0

Þ	Α	L	Α	Ç	M	,	O	_	TRANSLATES C	YMROIT	C EQUATIONS INTO PAL OBJECT	PALOOO PALOOO
•		-	n	-		-	٠				R DIRECT INPUT TO STANDARD	PALOOO
									PROM PROGRAM		A DINIGHT INTO I TO DINNOMAD	PALOOG
											•	PALOOD
									INPUT:	PAI.	ESIGN SPECIFICATION ASSIGNED	PALOOO
									101.		PD(1). OPERATION CODES ARE	PALOOO
											NED TO ROP(5).	PALOOD
`										4221	THED TO HOP (3).	PALOOI
									OUTPUT:	2040	SIMULATION, AND FUSE PATTERN	
									OULFUL.		ASSIGNED TO POF(6), HEX AND	PALOUI
											RY PROGRAMMING FORMATS ARE	PALOOI
											NED TO PDF(6). PROAPTS AND	PALOOI
									1			
											MESSAGES ARE ASSIGNED TO	PALOOI
										PMS (0	·) •	PALOOI
												PALCOI
									PART NUMBER:		PAL PART NUMBER MUST APPEAR	PALOOI
										IN CO	LUAN ONE OF LINE ONE.	PALOOI
												PALOOZ
									PIN LIST:		MBOLIC PIN NAMES MUST APPEAR	PALOU2
										START	ING ON LINE FIVE.	PALOUZ
												PALOUZ
									EQUATIONS:		ING FIRST LINE AFTER THE	PALOOZ
										PIN I	IST IN THE FOLLOWING FORMS:	PALODZ
												PALOOZ
										À	= 8 # C + D	PALOOZ
												PALOOZ
										A	:= b + C → D	PALOOZ
												PALOOS
									,	". IF	'( A#B ) C = D + E	PALOOS
												PALO03
										· A 2	? := (A1:*:B1) + /C	PALOOS
												PALO03
										ALL C	CHARACTERS FOLLOWING 1; ARE	PALOG
										IGNOR	RED UNTIL THE NEXT LINE.	PALO03
												PALOOS
										BLANK	S ARE IGNORED.	PALOOS
			•							`		PALOOS
									OPERATORS:	(IN	HIERARCHY OF EVALUATION )	PAL004
												PALO04
										;	COMMENT FOLLOWS	PALCOU
										/	COMPLEMENT	PALO04
										*	AND (PRODUCT)	PALO04
				,						1	OR (SUM)	PAL004
										: +:	XOR (EXCLUSIVE OR)	PALO04
										: *:	XNOR (EXCLUSIVE NOR)	PALO04
										( )	CONDITIONAL THREE-STATE	PALOU4
											OR FIXED SYMBOL	PALO04
										=	EQUALITY	PALOO5
									8	:=	REPLACED BY (AFTER CLOCK)	PALOUS
											•	PALO05
				•					FIXED SYMBOL	S.	**	PALOUS
									FOR PALIEX4			PAL 005
									AND PALIGA4			PALO05

FILE: PALZO F	CORTRAN	A NSC TIME	SHARING SERVICES VM/SP RELEASE 2.0	
( · c		ONLY:	(AN+/3N) WHERE N = 0,1,2,3	PAL00560
C			(NETRO TOTAL (NETRA)	PAL00570
C			(AN) 17, 16, 15, 14, RESP	PAL00580
С		:	(/AN+/3n) A IS OUTPUL	PAL00590
c			(/uh) B IS INPUT	PALOOGOU
Ç			(AN: +: 54)	PAL00610
c			(NF/4N9)	PALO0620
C C			(/AN+BN)	PAL00630
C			(AN: *: BN)	PAL00640
c			(⊔h) (AN⊄⊔N)	PALOJ653 PALOO660
C .			(/AS)	PAL00670
c			(/AN*/5N)	PAL00680
c ·			(/AN≠GN)	PAL00690
è			( )	PAL00700
c		FUNCTION	L. H. X. Z. AND C ARE VALID	21100710
c		TABLE:	FUNCTION TABLE VECTOR ENTRIES.	PAL00720
C C				PAL00733
c		REFERENCE:	A COMPLETE USERS GUIDE TO	PAL00740
C			DISIGNING WITH PALS USING PALASM	PALOU750
c			IS PROVIDED IN THE MONOLITHIC	PAL00760
С			MEMORIES PAL HANDBOOK.	PAL00770
C ·				PAL00780
С		: CZMITUOREUZ	INITLZ, GETSYM, INCR, MATCH, FIXSYM,	PAL00796
C .			IXLATE, ECHO, CAT, PINOUT, PLOT, TWEEK,	
C ·			BINH, HEX, SLIP, FANTOM, IODC2, IODC4,	PALOOSIO
c			TEST, FIXTST	PALOU620
C C		T FM 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	ARALEMAN ARRAMAN MERCETONI	PAL00830
		HEV LEVEL:	02/12/82 (VAX/VMS VERSION) 09/14/82 (SAI/SAO FAULT TESTING)	PAL00840 PAL00850
C			10/15/82 (JEDEC FORMAZ)	PAL00860
Č			By: Intiyaz Bengali	PAL00870
č			. by tacty de bongatt	DEBCOLAG
c		AUTHGAS:	JOHN BIRKNER AND VINCENT COLI	PAL 0 0 8 9 0
c			MONOLITHIC MEMORIES INC.	PAL00900
c ·			1165 EAST ARQUES AVENUE	OFFCOLAG
С			SUNNYVALE, CALIFORNIA 94043	PAL00920
C			(403) 739-3535	PAL00930
С				PAL00940
С		FINE PRINT:	MONOLITHIC MEMORIES TAKES NO	PAL 00950
C			RESPONSIBILITY FOR THE OPERATION	PAL00960
.c			OR MAINTENANCE OF THIS PROGRAM.	PAL00976
c .			THE SOURCE CODE AS PRINTED HERE	PAL00980
C			PRODUCED THE OBJECT CODE OF THE	PAL00990
C C			EXAMPLES IN THE APPLICATIONS SECTION ON A VAX/VMS 11/78J	PAL01000 PAL01010
C			COMPUTER AND A NATIONAL CSS IBM	PALO 1010
C			SYSTEM/370 FORTRAN IV (G).	PAL01030
C			SISTEMY FOR CONTRACT TO (O)	PAL01040
	***	*****	**********	
C				PALO-1060
Č				PAL01070
C * * * * * * * * * * * * * * * * * * *	*****	****	************	*PAL01000
<b>C</b> .				PAL01090
С				PAL01100

```
FILE: PALZO
                FORTRAN A
                              NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      MAIN PROGRAM
                                                                              PAL01110
                                                                              PAL01120
      IMPLICIT INTEGER (A-Z)
                                                                              PAL01130
      INTEGER IPAL (4) . REST (73) . PATNUM (60) . TITLE (80) . COMP (80) .
                                                                              PALO 1 140
               ISYM (8,20), 18UF (8,20)
                                                                              PALO1156
      LOGICAL LOLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR,
                                                                              PAL01160
     1
               LFIX, LFIRST, LMATCH, LFUSES (32,64), LPHASE (20), LBUF (20),
                                                                              PAL01170
     2
               LPROD (80), LSAME, LACT, LOPERR, LINP, LPRD, LERR, LSA11, LSA01
                                                                              PALO 1180
      INTEGER
                                                                              PAL01190
      COMMON
              LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR
                                                                              PAL01200
      COMMON /PGE/ IPAGE(80,200)
                                                                              PAL01210
      COMMON /LFUSES/LFUSES
                                                                              PALO 1220
      COMMON /LUNIT/ PMS, POF, PDF
                                                                              PALO 1230
      COMMON /FTEST/ IFUNCT, IDESC, IEND
                                                                              PAL01240
      DATA E/'E'/,0/'0'/,T/'T'/,P/'P'/,B/'B'/,H/'H'/,S/'S'/,L/'L'/,
                                                                              PAL01250
            N/'N'/,C/'C'/,Q/'Q'/,U/'U'/,F/'F'/,R/'R'/,A/'A'/,I/'I'/,
                                                                              PAL01260
            J/'J'/
                                                                              PAL01270
      DATA BB/'B'/,CC/'C'/,DD/'D'/,EE/'E'/,FF/'F'/,II/'I'/,JJ/'J'/,
                                                                              PAL01280
            NN/'H'/,OO/'O'/,PP/'P'/,RR/'R'/,SS/'S'/,TT/'T'/,UU/'U'/
                                                                              PAL01290
      DATA BEL/20700000/
                                                                              PALO 1300
С
                                                                              PAL01310
c
                                                                              PAL01320
C
      ASSIGNMENT OF DATA SET REFERENCES
                                                                              PAL01330
C
      RPD - PAL DESIGN SPECIFICATION (INPUT)
                                                                              PAL01340
C
      ROC - OPERATION CODE (INPUT)
                                                                              PAL01350
C
      POF - ECHO, PINOUT, TEST, AND PLOT (OUTPUT)
                                                                              PAL01360
c
      PDF - HEA AND BINARY FORMAT PROGRAM TAPES (OUTPUT)
                                                                              PAL01370
C
      PMS - PROMPTS AND ERROR MESSAGES (OUTPUT)
                                                                              PAL01380
      WRITE (6, 3)
                                                                              PAL01390
    3 FORMAT (/, PALASM VERSION 1,5')
                                                                              PALC 1400
      WRITE (6, 1)
                                                                              PAL01410
    1 FORMAT (/, WHAT IS THE LOGICAL UNIT NUMBER FOR OUTPUT (6) ?: ')
                                                                              PAL01420
      READ (5,2) LUN
                                                                              PAL01430
    2 FORMAT (I4)
                                                                              PAL0144U
      RPD=1
                                                                              PAL01450
      ROC=5
                                                                              PAL01460
      POF=6
                                                                              PAL01470
      PDF=6
                                                                              PAL01480
      PMS=10
                                                                              PAL01490
      TFUNCT=0
                                                                              PAL01500
      IDESC=0
                                                                              PAL01510
C
      INITIALIZE LSAME AND LACT TO FALSE (ACTIVE HIGH/LOW ERROR)
                                                                              PAL01520
      LSAME= FALSE.
                                                                              PAL01530
      LACT=.FALSE.
                                                                              PAL01540
С
      INITIALIZE LOPERS TO FALSE (OUTPUT PIN ERROR)
                                                                              PALO 1550
      LOPERR = . FALSE.
                                                                             PAL01560
c
      INITIALIZE LINP TO FALSE (INPUT PIN ERROR)
                                                                             PAL01570
      LINP= FALSE.
                                                                              PAL01580
c
      INITIALIZE LPRD TO FALSE (PRODUCT LINE ERROR)
                                                                             PAL01590
      LPRD= . FALSE.
                                                                            PAL01600
C
      READ IN FIRST 4 LINES OF THE PAL DESIGN SPECIFICATION
                                                                             PAL01610
      READ (RPD, 10) IPAL, INOAI, IOT, INOO, REST, PATNUM, TITLE, COMP
                                                                             PAL01620
   10 FORMAT (4A1, A1, A1, A1, 73A1, /, 80A1, /, 80A1, /, 80A1)
                                                                             PAL01630
C
      READ IN PIN LIST (LINE 5) THROUGH THE END OF THE PAL DESIGN
                                                                             PAL01640
       SPECIFICATION
                                                                             PAL01650
```

FILE: PAL20 FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0

```
DO 15 J=1,200
                                                                                PAL01660
           READ (RPD, 11, END=16) (IPAGE (I, J), I=1,80)
                                                                                PAL01670
   11
           FORMAT (BUA 1)
                                                                                PAL01680
                                                                                PAL01690
С
      CHECK FOR 'FUNCTION TABLE' AND SAVE ITS LINE NUMBER
                                                                                PAL01700
               IFUNCT, E2.0 .AND. IPAGE(1,J) .EQ. FF. AND.
      IF(
                                                                                PAL01713
           IPAGE (2, J) . EQ. UU. AND. IPAGE (3, J) . EQ. NN. AND.
     2
           IPAGE (4, J) . EQ.CC. AND. IPAGE (5, J) . EQ.TT. AND.
                                                                                PALO 1720
                                                                                PAL01730
           IPAGE (b, J) . EQ. II. AND . IPAGE (7, J) . EQ. OO. AND .
           IPAGE (8, J) . EQ. NN. AND. IPAGE (10, J) . EQ. TT. AND.
                                                                                PAL01740
     5
           IPAGE(12,J).LQ.BB.AND.IPAGE(14,J).EQ.EE ) IFUNCT=J
                                                                                PAL01750
C
      CHECK FOR 'DESCRIPTION' AND SAVE ITS LINE NUMBER
                                                                                PAL01760
                IDESC. EQ.O .ANJ. IPAGE (1, J) . EQ. DU. AND.
                                                                                PAL01776
           19AG2(2, J) . EQ. EE. AND. IPAGE(3, J) . EQ. SS. AND.
                                                                                PAL01780
           IFAGE (4.J) . EQ.CC. AND. IPAGE (5.J) . EQ.RR. AND.
                                                                                PAL01790
           IPAGE(6, J) .EQ.II.AND.IPAGE(7, J) .EQ.PP.AND.
                                                                                PAL01300
           IPAGE (8, J) .EQ.TT.AND.IPAGE (9, J) .EQ.II.AND.
                                                                                PAL01810
           IPAGE (10.J) . Ev. UO. AND. IPAGE (11.J) . EO. NN ) IDESC = J
                                                                                PAL01820
   15 CONTINUE
                                                                                DALO1830
                                                                                PAL01840
С
      SAVE THE LAST LINE NUMBER OF THE PAL DESIGN SPECIFICATION
                                                                                PAL01850
   16 IEND=J-I
                                                                                PAL01860
      CALL INITLZ (INOAI, IOT, INOO, ITYPE, LFUSES, IC, IL, IBLOW, LFIX, IPCIR)
      ILE=IL+1
                                                                                PAL01870
С
                                                                                PAL01880
      PRINT ERROR MESSAGE FOR INVALID PAL PART TYPE
      IF (ITYPE.NE.O) GO TO 17
                                                                                PAL01890
           WRITE (PMS, 18) IPAL, INOAI, IOT, INOO
                                                                                PAL01900
           FORMAT (/, PAL PART TYPE ', 4AI, AI, AI, AI, IS INCORRECT')
   18
                                                                                PAL01910
                                                                                PAL01920
           STOP
C
      GET 20 PIN NAMES
                                                                                PAL01930
   17 DO 20 J=1,20
                                                                                PAL01940
                                                                                PALU 1950
   20
           CALL GETSYM (LPHASE, ISYM, J, IC, IL, LFIX)
           IF (.NOT. (LEQUAL.OR.LLEFT.OR.LAND.OR.LOR.OR.LRIGHT)) GO TO 24
                                                                                PAL01960
                                                                                PAL01970
               WRITE (2M3, 23)
               FORMAT (/, LESS THAN 20 PIN NAMES IN PIN LIST')
   23
                                                                                PAL01980
                                                                                PAL01990
   24 ILE=IL
                                                                                PAL02000
C
      BYPASS FUSE PLOT ASSEMBLY IF HAL (H IN COLUMN 1, LINE 1)
                                                                                PALOZOIJ
                                                                                PAL02020
      IF ( IPAL(1), EQ, H ) GO TO 108
   25 CALL GERSYH (LBUF, IBUF, 1, IC, IL, LF14)
                                                                                PAL02030
                                                                                PALO2040
   28
           IF (.NOT.LEQUAL) GO TO 25
           COUNT=0
                                                                                PAL02050
                                                                                PAL02060
           ILL=IL
           CALL MATCH (IMATCH, IBUF, ISYM)
                                                                                PAL02070
                                                                                PAL02080
           IF ( LMATCH.EQ.O ) GO TO 100
                                                                                PAL02090
           IPRD=IMATCH
c
           CHECK FOR VALID POLARITY
                                                                                PAL02100
                            LPHASE (IMATCH)) . AND. (
                                                        LBUF(1)).OR.
                                                                                PALOZIIO
           LSAME = (
     1
                      (.NOT.LPHASE(IMATCH)).AND.(.NOT.LBUF(1)))
                                                                                PAL02120
                                                                                PAL02130
           IF ( IOT. EQ. H. AND. (. NOT. LSAME) )
                                                                LACT=.TRUE.
           IF ( (.NOT. (IOT. EQ.H.OR. IOT. EQ.C)). AND. (LSAME) ) LACT=.TRUE.
                                                                                PAL02140
                                                                                PAL02150
С
           CHECK FOR VALID OUTPUT PIN
           IF ( (ITYPE.EQ. 1.0h. ITYPE.EQ. 5.0R. ITYPE. EQ. 6) .AND. IOT. NE. A.
                                                                                PAL02160
     ı
           AND. (IHATCH.LT. 12.OR. IMATCH.GT. 19) ). LOPERR=. TRUE.
                                                                                PAL02170
           IF ( ITYPE, EQ. 2. AND. (IMATCH, LT. 13. OR, IMATCH, GT. 18) )
                                                                                PAL02180
                                                                                PAL02190
                                                    LOPERR=.TRUE.
     1
                                                                                PAL02200
                ITYPE.EQ. 3. AND. (IMATCH.LT. 14.0%. IMATCH.GT. 17) )
```

```
FILE: PAL20
                 FORTRAN
                                NSC TIME SHARING SERVICES VM/SP RELEASE 2,0
      1
                                                     LOPERR= . TRUE .
                                                                                  PAL02210
                                                                                  PAL02220
                ITYPE, EQ. 4, AND. (IMATCH, LT. 15, OR. IMATCH, GT. 16) )
     1
                                                                                  PAL02230
                                                     LOPERR= TRUE.
           IF ( (LACT) .OR. (LOPERR) ) GO TO 100
                                                                                  PAL02240
           183PRO= (19-IMATCH) #3 + 1
                                                                                  PAL02250
                                                                                  PAL02260
С
           START PALISCI ON PRODUCT LINE 24 (188PRO=25)
           IF (IUT. EQ.C) 183PRO=25
                                                                                  PAL02270
           TC = 0
                                                                                  PAL02280
   30
             CALL INCR (IC, IL, LFIX)
                                                                                  PAL02290
             IF ( .NOT. (LEQUAL. OR. LLEFT) ) GO TO 30
                                                                                  PAL02300
             LPROD (I88PRO) = . TRUE.
                                                                                  PAL02310
             IF ( (.NOT.LLEFT) .AND. (REST(3) .NE.PP) ) CALL SLIP(LFUSES.
                                                                                  PAL02320
     .
                 ISSPRO, INCAI, ICT, INCO, ILLOW)
                                                                                  PAL02330
           DO 70 18PRO=1,16
                                                                                  PAL02340
                COUNT = COUNT + 1
                                                                                  PAL02350
                IF ( (LXOR) . AND . IEPRO. NE. 5 ) GO TO 70
                                                                                  PAL02360
                IPROD = I88PRO + 16PRO - 1
                                                                                  PAL02370
                LPROD (IPROD) = . TRUE.
                                                                                  PAL02380
                LFIRST = . TRUE.
                                                                                  PAL02390
   50
                  ILL=IL
                                                                                  2AL02400
                  CALL GETSYM (LBUF, IBUF, 1, IC, IL, LFIX)
                                                                                  PAL02410
               IF ( (ITYPE.EQ. 1. OR. ITYPE. EQ. 2. AND. IPRD. GT. 13
                                                                                  PALC2420
     ١
                     AND IPRO LI 18) AND COUNT GT. 2 ) LPRD= TRUE.
                                                                                  PAL02430
                IF ( (ITYPE, EQ. 3.OR. ITYPE, Ly. 2. AND. (IPRD, EQ. 13.OR.
                                                                                  PAL02440
                     IPRD.EQ. 18)). AND. COUNT.GT.4 ) LPRD=.TRUE.
                                                                                  PAL02450
                IF ( IOT, NE. A. AND. IOT, NE.C. AND. COUNT, GT, 8 ) LPRD=, TRUE.
                                                                                  PAL02460
               IF ( .NOT. LPRD ) GO TO 69
                                                                                  PAL02470
                IF (IL. NE. IFUNCY. AND. IL. NE. IDESC) ILL=IL
                                                                                  PAL02480
               IPROD = IPROD - 1
                                                                                  PAL02490
               GO TO 118
                                                                                  PAL02500
   69
                  1F (LFIX) GO TO 59
                                                                                  PALO 2510
                  CALL MAICH (IMATCH, IBUF, ISYM)
                                                                                  PAL02520
                                                                                  PAL02530
                  CHECK FOR INVALID INPUT PIN
                  IF ( ITYPE.EQ. 1. AND. (AMATCH.GE. 12. AND. IMATCH.LE. 19) )
                                                                                  PAL02540
     1
                                                                                  PALO 2550
                      LINP= TRUE.
                  IF ( ITYPE, 22, 2, AND, (IMATCH, GE, 13, AND, IMATCH, LE, 18) )
                                                                                  PAL02560
     ì
                      LINP= TRUE.
                                                                                  PAL02570
                  IF ( ITYPE, EQ. 3. AND. (IMATCH, GE, 14. AND. IMATCH, LE, 17) )
                                                                                  PAL02580
     1
                      LINP= . TRUE.
                                                                                  PAL02590
                  IF ( ITYPE, EQ. 4, AND. (IMATCH, EQ. 15, OR. IMATCH, EQ. 16) )
                                                                                  PAL02600
     1
                      LINP= TRUE.
                                                                                  PAL02610
                  IF ( ITYPE, Eq. 5, AND. (IMATCH, Eq. 12. OR. IMATCH, Eq. 19) )
                                                                                  PAL02620
     ١
                      LINP=.TRUE.
                                                                                  PAL02630
                  IF ( TYPE.EQ. 6. AND. (IMATCH.EQ. 1. OR. IMATCH.EQ. 11) )
                                                                                  PAL02640
                      LINP= . TRUE.
                                                                                  PAL02650
                  ILL=1L
                                                                                  PAL02660
                  IF (LINP) GO TO 100
                                                                                  PAL02670
                  IF ( IMATCH, EQ. 0 ) GG TO 100
                                                                                  PAL02680
                  IF ( IMATCH.EQ. 10. OR. IMATCH. EQ. 99 ) GO TO 64
                                                                                  PAL02690
                  IF (.NOT, LFIRST) GO TO 58
                                                                                  PAL02700
                      LFIRST = . FALSE .
                                                                                  PALO2710
                      DO 56 I=1,32
                                                                                  PAL02720
                           IBLOW = IBLOW + 1
                                                                                  PAL02730
   56
                           LFUSES (I, IPROD) = . TRUE.
                                                                                  PAL02740
   58
                  CALL IXLATE (IINPUT, IMATCH, LPHASE, LBUF, ITYPE)
                                                                                  PAL02750
```

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FILE: PAL20
               FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.U
                                                                             PAL02760
                 IF (IINPUT.LE.O) GO TO 60
                 IBLOW = IBLOW - 1
                                                                             PAL0277U
                 LFUSES (IINPUT, IPAOD) = . FALSE.
                                                                             PAL02780
                 CALL PLOT (LBUF, LBUF, LFUSES, 12ROD, TITLE, .FALSE., 1TYPE,
                                                                             PALO2790
                           LPROD, IUP, IBLUM, IPCTH)
                                                                             PALO2800
                 GO TO 60
                                                                             PAL02810
   59
                 CALL FIXSIM (LBUF, 18UF, IC, IL, LFIRST, LFUSES, IBLOW,
                                                                             PAL02820
                             (XIII.COAGI
                                                                             PAL02830
   60
                IF (LAND) GO TO 50
                                                                             PAL02840
   54
              IF (. NOI. LRIGHT) GO TO 68
                                                                             PAL02850
   66
                CALL INCR (IC, IL, LFIX)
                                                                             PAL02860
                                                                            PAL02870
                IF (.NOT.LEQUAL) GO TO 66
               IF ( .NOT. (LOR.OR.LEQUAL) ) GO TO 74
   ი მ
                                                                            PAL02880
   70
              CONFINUE
                                                                             PAL02890
   74
          [LL=IL
                                                                             PAL02900
          CALL GETSYM (LBUF, 1BUF, 1, TC, IL, LFIX)
                                                                             PAL02910
          IF (LLEFT. OR. LEQUAL) GO TO 28
                                                                            PAL02920
  100 IF ( ILL. Eg. IFUNCT, OR. ILL, Eg. IDESC ) GO TO 102
                                                                             PAL02930
      PRINT AN ERROR MESSAGE IF UNRECOGNIZABLE SYMBOL
C
                                                                            PAL02940
                                                                            PALO2950
      ILERR=ILL+4
      WRITE (PMS, 99) BEL
                                                                             PAL02960
                                                                            PAL02970
   99 FORMAT ( 1 4, A 1).
      WRITE (285, 101) (IBUF(1, 1), I=1,0), ILERR, (IPAGE(I, ILL), I=1,00)
                                                                            PAL02980
  101 FORMAT (/, ' ERROR SYMBOL = ', 8A1, ' IN LINE NUMBER ', 13,
                                                                            PALU299U
             7,1 1,3021)
                                                                            PAL03000
Ç
      PRINT AN ERROR MESSAGE FOR ACTIVE HIGH/LOW PART
                                                                            PAT 0 3010
      IF ( (LACT) . AND. ( LSAME) . AND. (.NOT. LOPERR) )
                                                                            PAI.03020
               WRITE (PMS, 103) IPAL, INOAL, LOT, INOO
                                                                            PALOZOGO
  103 FORMAT(' OUTPUT HUST BE INVESTED SINCE ',4A1,A1,A1,A1,
                                                                            PAL03040
              ' IS AN ACTIVE LOW DEVICE")
                                                                          PAL03050
      IF ( (LACT) . AND. (.NOT.LSAME) . AND. (.NOT.LOPERR) )
                                                                            PAL03060
               WRITE (PMS, 199) IPAL, INOAL, TOT, INOO
                                                                            PAL03070
  109 FORMAT ( OUTPUT CANNOT BE INVERTED SINCE 1,441,41,41,41, ...
                                                                            PALOSOSO
             ' IS AN ACTIVE HIGH DEVICE')
                                                                            PAL03090
C
      PRINT AN ERROR MESSAGE FOR AN INVALLE OUTPUT PIN-
                                                                            PAL0310U
      IF ( (LOPERR) . AND . IMATCH . NE. 0 )
                                                                         CILECTAR
               WRITE (PMS, 105) IMATCH, IPAL, INOA1, IOT, INOO
                                                                           PALC3120
  105 FORMAT( This Pin Number ', 12, ' is an invalid output Pin', ...
                                                                            PAL03130
             * FOR * ,4A1, A1, A1, A1)
                                                                            PALO 3 140
C
      PRINT AN ERROR MESSAGE FOR AN INVALID INPUT PIN
                                                                            PAL03150
      IF (LIMP) WRITE (PMS, 115) IMATCH, IPAL, INO. 41, IOT, INO.
                                                                            PAL03160
  115 FORMAT (' THIS PIN NUMBER ',12, ' IS AN INVALID INPUT PIN', PALO3170
             1 FOR 1,4A1,A1,A1,A1)
                                                                            PAL03180
C
      PRINT AN ERROR MESSAGE FOR INVALID PRODUCT LINE
                                                                            PAL03190
  118 ILERR=ILL+4
                                                                            PAL03200
                                                                            PAL03210
      IF (LPRD) WRITE (PMS, 119)
     1 (ISYM(I, IPRD), I=1,8), IPRD, ILEAR, (IPAGE(I, ILL), I=1,80)
                                                                            PAL03220
  119 FORMAT (/, OUTPUT PIN NAME = ', BAI, OUTPUT PIN NUMBER = ', I2, PALO3230
             /, dinterm in Line Number ', 13, /, ' ', soat)
                                                                            PAL03240
                                                                            PAL03250
      IF ( LPAD.AND.COUNT.LI. 3 )
  I WRITE (PMS, 116) IPHOD, IPAL, INAI, TOT, ITAL (116 FORMAT (* THIS PRODUCT LINE * 1,12, * IS NOT VALID*,
               OCKI, TOI, IAOKI, LAGI, COHGI (811, 2MS) BIIRW
                                                                            PAL03260
                                                                            PAL03270
             ' FOR ',4A1,A1,A1,A1)
                                                                            PAL03280
     1
                                                                            PAL03290
     IF ( LPRD, AND, COUNT, GT. 8 )
                                                                            PAL03300
               WRITE (PMS, 117) IPAL, INDAI, 10T, 1NOO
```

```
FILE: PAL20
              117 FORMAT(' MAXIUM OF & PRODUCT LINES ARE VALID FOR '.4A1.A1.A1.A1.
                                                                             PAL03310
                                                                             PAL03320
     /, TOO MANY MINTERMS ARE SPECIFIED IN THIS EQUATION*)
                                                                             PAL03330
                                                                             PALO3340
  102 IF (ITYPE.LE.4) CALL TWEEK (ITYPE.10T.LFUSES)
                                                                             PAL03350
  108 WRITE (6, 106)
                                                                             PAL03360
  106 FORMAT (/, ' OPERATION CODES: ')
      WRITE (6, 107)
                                                                             PAL03370
  107 FORMAT(/, 'E=ECHO INPUT O=PINOUT T=SIMULATE P=PLOT B=BRIEF', 'I H=HEX S=SHORT L=BHLF N=BNPF C=CATALOG Q=QUIT',
                                                                             PALO3380
                                                                             PAL03390
              /, F=FAULT TESTING J=JEDEC FORMAT')
                                                                             PAL03400
      WRITE (6, 110)
                                                                             PAL03410
                                                                             PAL03420
  110 FORMAT (/, ' ENTER OPERATION CODE: ')
      READ (ROC, 120) IOP
                                                                             PAL03430
  120 FORMAT (A1)
                                                                             PAL03440
      CALL TODC 2
                                                                             PAL03450
      IF (POF. NE.6) WRITE (POF. 125)
                                                                             PAL03460
  125 FORMAT ('1')
                                                                             PAL03470
      IF (IOP. E. E. CALL ECHO (IPAL, INOAL, IOT, INOO, REST, PATNUM, TIPLE,
                                                                             PAL03483
                                                                             PAL03490
                               COMP)
                                                                             PAL03500
      IF (IOP.EQ.O) CALL PINOUT (IPAL, INVAI, IOT, INOO, TIPLE)
      IF (IOP. EQ.T) CALL TEST (LPHASE, LBUF, TITLE, IC, IL, ILE, ISYM, IBUF,
                                                                             PAL03510
                               ITYPE, INOO, LFIX, IPCTR, LERR, ISAF, IPCTR1,
                                                                             PAL03520
                                                                             PAL03530
                               .FALSE., .FALSE.)
                                                                             PAL03540
С
      INITIALIZING THE TOTAL FAULTS. CALLING FOR SAI/SAO TEST
                                                                             PAL03550
      IJAF=0
                                                                             PAL03560
      IF (IOP. EQ. F) GO TO 200
      IF (IOP. EQ. JJ) CALL PLOTF
                                                                             PAL03570
  135 IF (IOP, EV, P) CALL PLOT (LBUF, IBUF, LFUSES, IPROD, TITLE, TRUE, ITYPE, PALO3580
                               LPROD, IOP, IBLOW, IPCTRO)
      IF (IOP. EQ. B) CALL PLOT (LBUF, IBUF, LFUSES, IPROD, TITLE, TRUE, ITYPE, PALO3600
                               LPROD, IOP, IBLOW, IPCTRO)
                                                                             PAL03610
      IF (IOP.EQ.H) CALL HEX (LFUSES, H)
                                                                             PAL03620
      IF (IOP. EQ. S) CALL HEX (LFUSES, S)
                                                                             .PAL03630
      IF (IOP.EQ.L) CALL BINK (LFUSES, H, L)
                                                                             PAL03640
      IF (IOP. EQ. N) CALL BINE (LEUSES, P, N)
                                                                             PAL03650
      IF (IOP.EQ.C) CALL CAT
                                                                             PAL33660
                                                                             PAL03670
С
      CALL IODC4
      IF (IOP.NE.Q ) GO TO 108
                                                                             PAL03680
                                                                             PAL03690
C
                                                                             PAL03700
      SETTING THE PARAMETERS FOR SA1/SAO TESTS
                                                                             PAL03710
  200 IPCTR=0
                                                                             PAL03720
      CALL TEST (LPHASE, LBUF, TITLE, IC, IL, ILE, ISYM, IBUF, ITYPE,
                                                                             PAL03730
                                                                             PAL03740
                 INOO, IFIX, IPCTR, LERR, ISAF, IPCTR1., FALSE., .. FALSE.)
      IPCTRO=IPCTR
                                                                             PAL03750
                                                                             PAL03760
C
      LOOPING FOR SAI TEST
                                                                             PAT.03770
      DO 210 IPCTR1=1, IPCTRO
                                                                             PAL03780
      LSA 11= TRUE.
      CALL TEST (LPHASE, LBUF, TITLE, IC, IL, ILE, ISYN, IBUF, ITYPE,
                                                                             PAL03790
                 INOO, IF1X, IPCTR, LERR, ISAF, IPCTR1, LSA11, .FALSE.)
                                                                             PAL03800
  210 CONTINUE
                                                                             DALGRAID
                                                                             PAL03820
      ISA1=ISAF
С
      LOOPING FOR SAO TEST
                                                                             PAL03830
                                                                             PAL03840
      DO 215 IPCTR1=1, IPCTRO
                                                                             PAL03850
      LSAO1=, TRUE,
```

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FILE: PALZO FORTRAN A
                           NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      CALL TEST (LPHASE, LBUF, TITLE, IC, IL, ILE, ISYM, IBUF, ITYPE,
                                                                          PAL03860
                                                                           PAL03870
                INOO, IFIX, IPCTR, LERR, ISAF, IPCTR1, FALSE, LSAG1)
                                                                           C88ED1A9
  215 CONTINUE
      ISAO=ISAF-ISA1
                                                                           PAL03890
      IFAULT = (13AF + 100) / (IPCTR0 + 2)
                                                                           PAL03900
      WRITE (POF, 220) ISA1
                                                                           PAL03910
                                                                           PAL03920
  220 FORMAT(/, NUMBER OF STUCK AT ONE (SAI) FAULTS ARE = 13)
      WRITE (POF, 225) ISAO
                                                                           PALC3930
 225 FORMAT(/, NUMBER OF STUCK AT ZERO (SAO) FAULTS ARE = 1 13)
                                                                           PAL03940
      WRITE (POF, 230) IFAULT
                                                                           2AL03950
  230 FORMAT (/, PRODUCT TERM COVERAGE
                                                            = 1 IJ, 1%1,//) PAL03960
      GO TO 135
                                                                           PAL03970
С
                                                                           PAL03980
      FMD
                                                                           PAL03990
C
                                                                           PALG400C
   C
                                                                           PALC4010
С
  THE FOLLOWING SUBROUTINE GIVES JEDEC FORMATTED OUTPUT FOR
                                                                           PAL04020
   PROGRAMMING COMPATIBILITY WITH DATA 1/O PROGRAMMERS
                                                                          PAL04030
      SUBROUTINE PLOTE
                                                                           PAL04040
      IMPLICIT INTEGER (A-2)
                                                                           PAL04050
      LOGICAL
               LFUSES (32,64)
                                                                           PALO4060
      INTEGER 12BUF (32), ZERO, ONZ
                                                                           PAL04070
      INTEGER 1SUM (4), IADR, STX, ETX, IDEC (4), IPT, IINP, J1, J2
                                                                           PAL04080
      INTEGER IDECIO(4), ISUMV(4), ISUMIO(4), BUFIO(32)
                                                                          PAL04090
      COMMON /LUNIT/ PMS, POF, PDF
                                                                           PAL04100
      COMMON
              /IPT/ IPT
                                                                           PAL04110
      COMMON
             /LFUSES/ LTUSES
                                                                           PAL04-120
      COMMON /SUM/ ISUM, IDEC, IPBUF, BUFIO
                                                                           2AL04130
              ZERO/!C'/, ONE/!!!/
                                                                           PAL04140
      DATA
                                                                           PAL04150
      TABRED
      STX = 2
                                                                           2AL04160
                                                                           PAL04170
      ETX = 3
                                                                           PALU4180
      ISUM (2) = 0
                                                                           PAL04 190
      ISUM (4) = 230
                                                                           PAL04200
      WRITE (PDF, 10) STX
   10 FORMAT (' ', à 1, ' # F 0 # ')
                                                                           PAL04210
      DO 300 IPT=1,64
                                                                           PAL04220
      DO 50 IINP=1,32
                                                                           PAL04230
      IF (LFUSES (IINP, IPT)) IPBUF (IINP) = ONE
                                                                          PAL04240
      IF (.NOT. (LFUSES (IINP, 1PT))) 128UF (IINP) = ZERO
                                                                          PAL04250
   50 CONTINUE
                                                                          PAL04260
      IF(LFUSES(1,1PT)) GO TO 100
                                                                          PAL04270
      IF(.NOT.LFUSES(2,IPT)) GO TO 250
                                                                          PAL04280
  100 IDEC (4) = 1 ADR
                                                                           PAL04290
      DO 150 J=1.3
                                                                           2AL04300
                                                                           PAL04313
      J1=5-J
                                                                           PAL04320
      J2=4-J
      IDEC (J2) = IDEC (J1) / 10
                                                                           PAL04330
      IDEC (J1) = IDEC (J1) - 10*IDEC (J2)
                                                                           PAL04340
      IDECIO(J1) = ICONV(IDEC(J1))
                                                                           PAL04350
  150 CONTINUE
                                                                           PAL04360
      IDECIO(1) = ICONV(IDEC(1))
                                                                           PAL04370
                                                                           PAL04380
      CALL SUMCHK
      WRITE (PDF, 201) 1DECIO, IPBUF
                                                                           PAL04390
  201 FORMAR(' L', 4A1, ' ', 3 (4A1, ' '), '*')
                                                                           PAL044CU
```

```
NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
FILE: PALZO . FORTRAN
  250 IADR=IADR+32
                                                                            PAL04410
  300 CONTINUE
                                                                            PALO4420
      ISUMIO(1) = ICONV (ISUM(2)/16)
                                                                            PAL04430
      ISUM(2) = MOD(ISUM(2), 16)
                                                                            PAL04440
      ISUMIO(2) = ICONV(ISUM(2))
                                                                            PAL04450
      ISUMIO(3) = ICONV (ISUM(4) \nearrow16)
                                                                            PAL04460
      ISUM(4) = MOD(ISUM(4), 16)
                                                                            PAL04476
      ISUMIO(4) = ICONV(ISUM(4))
                                                                            PAL04480
      WRITE (PDF, 400) ETX, ISUMIO
                                                                            PAL04490
  400 FORMAT(' *', A1, 4A1, '*',/)
                                                                            PAL04500
      RETURN
                                                                            PAL04510
      FND
                                                                            PAL04520
                                                                            PAL04530
************* PAL04540
C
                                                                            PAL04550
C THIS SUBROUTINE CALCULATES THE SUNCHECK
                                                                            PAT.04560
      SUBROUTINE SUNCHK
                                                                            PAT.04570
      IMPLICIT INTEGER (A-Z)
                                                                            PAL04580
      LOGICAL LFUSES (32,64)
                                                                            PAL04590
      INTEGER IPBUF (32), BUFIO (32)
                                                                            PAL 04600
      INTEGER ISUM (4), IDEC (4)
                                                                            PAL04610
      COMMON /IPT/ IPT
                                                                            PAL04620
      COMMON /LFUSES/ LFUSES
                                                                            PAL04630
      COMMON/SUM/ ISUM, IDEC, IPBUF, BUFIO
                                                                            PAL04640
      DO 50 J=1.32
                                                                            PAL04650
      IF (LFUSES (J, IPT)) BUF10 (J) =49
                                                                            PAL04660
      IF (.NOT.LFUSES (J.IFT) ) BUFIO (J) = 48
                                                                            PAL04670
      ISUM(4) = ISUM(4) + BUFIO(J)
      IF (ISUM (4) .GE. 256) ISUM (2) = ISUM (2) +1
                                                                            PAL04690
      ISUM (4) = MOD (ISUM (4), 256)
                                                                            PAL04700
   50 CONTINUE
                                                                            PAL04710
      DO 100 J=1,4
                                                                            PALC4720
      ISUM (4) = ISUM (4) + IDEC (J) +48
                                                                            PAL04730
      IF (ISUM (4) .GE, 256) ISUM (2) = ISUM (2) +1
                                                                            PAL04740
      ISUM(4) = MOD(ISUM(4), 256)
                                                                            PAL04750
  100 CONTINUE
                                                                            PAL04760
      ISUM(4) = ISUM(4) + 173
                                                                            PAL04770
      ISUM(2) = ISUM(2) + 1
                                                                            PAL04780
      IF (ISUM (4), GE, 256) ISUM (2) = ISUM (2) +1
                                                                            PAL04790
      ISUM (4) = MOD (ISUM (4), 256)
                                                                            PAL04800
      RETURN
                                                                            PAL04810
      END
                                                                            PAL04820
C * *
    **********
                                                                            PAL04830
С
                                                                            PAL04840
c
                                                                            PAL04850
      INTEGER FUNCTION ICONV(K)
                                                                            PAL04860
      IMPLICIT INTEGER (A-Z)
                                                                            PAL04870
      DATA A/101/, B/111/, C/121/, D/131/, E/141/, F/151/, G/161/, H/171/
                                                                            PAL04880
      DATA I/'8'/,J/'9'/,X/'A'/,L/'B'/,M/'C'/,N/'D'/,O/'E'/,P/'F'/
                                                                            PAL04890
      IF (K, EQ, 0) ICONV = A
                                                                            PAL 04900
      IF (K.EQ.1) ICONV=B
                                                                            PAL04910
      IF (K, EQ, 2) ICONV=C
                                                                            PAL04920
      IF (K.EQ.3) ICONV=U
                                                                            PAL04930
      IF (K.EQ.4) ICONV=E
                                                                            PAL04940
      IF (K, EQ.5) ICONV=F
                                                                            PAL04950
```

```
FILE: PAL20
               FORTRAN A
                           NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      IF (K.E2.6) ICONV=G
                                                                          PAL04960
      IF (K.EQ.7) ICONV=H
                                                                          PAL04970
      IF (K.EQ. 0) ICONV=I
                                                                          PAL04980
      IF (K.EQ.9) ICONV=J
                                                                          PAL04990
      IF (K, EQ, 10) ICONV=X
                                                                          PAL05000
      IF (K.E2.11) ICONV=L
                                                                          PAL05010
      IF (K.E. 12) ICONV=H
                                                                          PAL05020
      IF (K, EQ, 13) ICONV=N
                                                                          PAL05030
      IF (K, \Sigma_2, 14) ICONV=0
                                                                          PAL05040
      IF (K, EQ, 15) ICONV=P
                                                                          PAL05050
      RETURN
                                                                          PALC5060
      END
                                                                          PAL05070
C
                                                                          PAL05080
С
                                                                          PAL05090
PAL05110
      SUBROUTING INITLE (INOAL.IOT, INOO.ITYPE, LFUSES, IC.IL.IBLOW.LFIX.
                                                                          PAL05120
                        IPCTR)
                                                                          PAL05130
C
      THIS SUBROUTINE INITIALIZES VARIABLES AND MATCHES PAL PART
                                                                          PAL05140
C
      NUMBER WITH ITTPE
                                                                          PAL 35 150
      IMPLICIT INTEGER (A-Z)
                                                                          PALOS 160
      LOGICAL LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR,
                                                                          PAL05170
              LFIX, LFUSES (32, 64)
                                                                         PAL 05 180
      COMMON LBLANK, LLEFF, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR
                                                                          PAL05 190
      COMMON /PGE/ IPAGE(80,200)
                                                                          PAL05200
      DATA H/'H'/, L/'L'/, C/'C'/, R/'R'/, X/'X'/, A/'AT/,
                                                                          PAL05210
           10/101/,12/121/,14/141/,16/161/,18/181/
                                                                          PAL05220
С
      INITIALIZE LEUSES ARRAY (FUSE ARRAY)
                                                                          PAL05230
      DO 20 J=1,64
                                                                          PAL05240
         00 20 1=1.32
                                                                          PAL05250
   20
            LFUSES (I, J) = . FALSE.
                                                                         PAL05260
С
      INITIALIZE IBLOW (NUMBER OF FUSES BLOWN)
                                                                         PAL05270
                                                                          PAL05280
      IBLOM=0
C
      INITIALIZE IPCTR (NUMBER OF PRODUCT TERMS)
                                                                         PAL05290
                                                                          PAL05300
C
      INITIALIZE IC AND IL (COLUMN AND LINE POINTERS)
                                                                          PAL05310
      IC=0
                                                                          PAL05320
      IL=1
                                                                          PAL05336
      INITIALIZE ITYPE (PAL PART TYPE)
                                                                         PAL05340
      ITYPE=0
                                                                          PAL05350
С
      ITYPE IS ASSIGNED THE FOLLOWING VALUES FOR THESE PAL TYPES:
                                                                         PAL05360
c
           BIOLING, BHOLING
                                                     ITYPE=1
                                                                          PAL05370
c
           PAL-12H6, PAL 12L6
                                                                          PAL05380
                                                     TTYPF=2
c
           PALIGHA. PALIGLA
                                                     ITYPE=3
                                                                          PAL05390
С
           PALIGHZ, PALIGLZ, PALIGCT
                                                     ITYPE=4
                                                                          PAL05400
С
           PALIGLA
                                                     ITYPE=5
                                                                         PAL05410
c
           PALIGRA, PALIGRG, PALIGRA, PALIGRA, PALIGRA ITYPE=6
                                                                         PAL05420
c
      DETERMINE ITYPE
                                                                         PAL05430
      IF( INOAL.EQ.10)
                                                     ITYPE=1
                                                                          PAL05440
                                                                       PAL05450
      IF ( INOAT.EQ.12 )
                                                     ITYPE=2
      IF ( INOAI.EQ.14 )
                                                     ITYPE=3
                                                                         PAL05460
      IF ( (INOAL.EQ.16) )
                                                     ITYPE=4
                                                                         PAL05470
      IF ( (INOAI.EQ.16).AND. (INOO.EQ.18) )
                                                                         PAL05480
                                                    ITYPE=5
      IF ( (IOT.EQ.R).OR.(IOT.EQ.X).OR.(IOT.EQ.A) ) ITYPE=6
                                                                         PAL05490
                                                                         PALOSSOU
      IF ( .NOT. (IOT. EQ. H. OR. IOT. EQ. L. OR. IOT. EQ. C
```

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FILE: PAL20
               FORTRAN A
                            NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
            OR, IOT, EQ. R. OR, IOT, EQ. X. OR, IOT, EQ. A) ) ITYPE=0
                                                                        PAL05510
                                                                        PAL05520
     CALL INCR (IC, IL, LFIX)
                                                                        PAL05530
     RETURN
     END
                                                                        PAL05540
                                                                        PAL05550
c
PAL05570
C
     SUBROUTINE GETSYM (LPHASE, ISYM, J, IC, IL, LFIX)
                                                                        PAL05580
c
     THIS SUBROUTINE GETS THE PIN NAME, / IF COMPLEMENT LOGIC, AND
                                                                        PAL05590
С
       THE FOLLOWING OPERATION SYMBOL IF ANY
                                                                        PAL05600
     IMPLICIT INTEGER (A-Z)
                                                                        PAL05610
      INTEGER ISYM (8,20)
                                                                        PALOS620
     LOGICAL LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR,
                                                                        PAL05630
              LFIX, LPHASE (20)
                                                                        PAL05640
     COMMON
             LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR
                                                                        PAL05650
                                                                        PAL 05 660
     COMMON /PGE/ IPAGE(80.200)
     DATA IBLANK/ 1/
                                                                        PAL05670
     LFIX=.FALSE.
                                                                        PAL05680
     IF ( .NOT. (LLEFT.OR.LAND.OR.LOR.OR.LEQUAL.OR.LRIGHT) ) GO TO 10
                                                                        PAL05690
     CALL INCR (IC, IL, LFIX)
                                                                        PAL05700
      IF(LLEFT) GO TO 60
                                                                        PAL05710
   10 LPHASE (J) = ( .NOT. LSLASH )
                                                                        PAL05720
      IF (LPHASE (J)) GO TO 15
                                                                        PAL05730
      CALL INCR (IC, IL, LFIX)
                                                                        PAL05740
   15 DO 20 I=1,8
                                                                        PAL05750
  20
         ISYM(I,J)=IBLANK
                                                                        PAL05760
  25 DO 30 I=1,7
                                                                        PAL05770
  30
                                                                        PAL05780
          ISYM(I,J) = ISYM(I+1,J)
                                                                        PAL05790
      ISYM(8, J) = IPAGE(IC, IL)
     CALL INCR (IC, IL, LFIX)
                                                                        PAL05800
      IF ( LLEFT. OR. LBLANK. OR. LAND. OR. LOR. OR. LRIGHT. OR. LEQUAL ) RETURN
                                                                        PAL05810
     GO TO 25
                                                                        PAL05820
  60 LFIX= TRUE.
                                                                        PAL05830
      RETURN
                                                                        PAL05840 -
     END
                                                                        PAL05850
С
                                                                        PAL05860
C
                                                                        PAL05880
     SUBROUTINE INCH (IC, IL, LFIX)
                                                                        PAL05890
     THIS SUBROUTINE INCREMENTS COLUMN AND LINE POINTERS
c
                                                                        PALOS900
      BLANKS AND CHARACTERS AFTER 1: ARE IGNORED
                                                                        PAL05910
     IMPLICIT INTEGER (A-Z)
                                                                        PAL05920
     LOGICAL LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR,
                                                                        PAT.05930
              LFIX.LX1
                                                                        PAL05940
     COMMON LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR
                                                                        PAL05950
     COMMON /PGE/ IPAGE(80,200)
                                                                        PAL05960
     COMMON /LUNIT/ PMS, POF, PDF
                                                                        PAL05970
     DATA IBLANK/ 1/, ILEFT/ (1/, IAND/ 1*1/, IOR/ 1+1/, COMENT/ 1;1/,
                                                                        PAL05980
           ISLASH/'/', IEQUAL/'='/, IRIGHT/')'/, ICOLON/':'/
                                                                        PAL05990
                                                                        PAL06000
     LBLANK=.FALSE.
     LXOR= . FALSE.
                                                                        PAL06010
     LXNOR=. FALSE.
                                                                        PAL06020
     LX 1= . FALSE.
                                                                        PAL06030
                                                                        PAL06040
      LRIGHT= . FALSE .
   10 IC=IC+1
                                                                        PAL06050
```

```
NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      IF (IC .LE.79 .AND. IPAGE(IC, IL) .NE.COMENT) GO TO 30
                                                                            PALO6060
      IL=IL+1
                                                                            PAL0607J
      IF (IL.LE.200) GO TO 20
                                                                            PAL06080
          WRITE (PMS, 15)
                                                                            PAL06090
          FORMAT (/, ' SOURCE FILE EXCEEDS 200 LINES OR MISSING',
   15
                                                                            PAL06100
                    ' DESCRIPTION OR FUNCTION TABLE KEY WORD')
                                                                            PAL06110
                                                                            PAL06120
   20 IC=0
                                                                            PAL06130
      GO TO 10
                                                                            PAL06140
   30 IF ( IPAGE(IC, IL), EQ. ICOLON, AND. (LFIX) ) RETURN
                                                                            PALO6150
      IF ( IPAGE (IC, IL) . NE, IBLANK ) GO TO 31
                                                                            PALO6 163
          LBLANK= TRUE.
                                                                            PAL06170
          GO TO 10
                                                                            PAL0618J
   31 IF ( IPAGE (IC, IL) . NE, ICOLON ) GO TO 32
                                                                            PAL06190
      IF ( (LXOR) .OR. (LXNOH) ) GO TO 33
                                                                            PAL06200
      LKI= . TRUE .
                                                                            PAL06213
      GO TO 10
                                                                            PAL06220
                                                                            PAL06230
   33 IF (LXOR)
                 LOR= TRUE.
      IF (LXNOR) LAND = . TRUE.
                                                                            PAL06240
                                                                            PAL06250
      RETURN
   32 IF ( .MOT. (LXI.AND. (IPAGE (IC, IL) .EV, IOR, OR, IPAGE (IC, IL) .EV, IAND)) ) PALO6260
           GO TO 34
                                                                            PAL06270
      IF ( IPAGE (IC.IL) . EQ.IOR ) LXOR=.TRUE.
                                                                            PAL06280
                                                                            PAL06290
      IF ( IPAGE (IC, IL) . EQ. IAND ) LXNOR=. TRUE.
      GO TO 10
                                                                            PAL06300
   34 LLEFT = ( IPAGE (IC, 1L) . EQ. ILEFT
                                                                            PAL06310
      LAND = ( IPAGE (IC, IL) . EQ. IAND
                                                                            PALU6320
                                        )
      LOR
           = ( IPAGE (IC, IL) .EQ. 108
                                                                            PAL06330
      LSLASH= ( IPAGE(IC,IL) . 62.15LASH )
                                                                            PAL06340
      LEQUAL= ( IPAGE (IC, IL) . EQ. IEQUAL )
                                                                            PAL06350
                                                                            PAL06360
      LRIGHT= ( IPAGE (IC.IL) . EQ; IRIGHT )
      RETURN
                                                                            PA1.06370
      END
                                                                            PAL06380
С
C
      SUBROUTINE MATCH (IMATCH, IBUF, ISYM)
C
      THIS SUBROUTINE FINDS A MATCH BETWEEN THE PIN NAME IN THE EQUATIONPALO6430
c
       AND THE PIN NAME IN THE PIN LIST OR FUNCTION TABLE PIN LIST
                                                                            PAL06440
      IMPLICIT INTEGER (A-Z)
                                                                            PALG6450
      INTEGEA 1BUF (9, 20), 15YM (8, 20)
                                                                            PAL06460
      LOGICAL LMATCH
                                                                            PAL06470
      DATA C/'C'/, A/'A'/, R/'R'/, Y/'Y'/
                                                                            PAL06480
                                                                            PAL06490
      IMATCH=0
      DO 20 J=1,20
                                                                            PAL06500
                                                                            PAL06510
          LMATCH= . TRUE .
                                                                            PAL06520
          00 10 I=1.8
   10
                                                                            PAL06530
              LMATCH=LMATCH, AND, (IBUF (I, 1) . EQ, ISYM (I, J))
          IF (LMATCH) IMATCH=J
                                                                            PAL06540
          CONTINUE
                                                                            PAL06550
   2.0
c
                                                                            PAL06560
      MATCH CARRY WHICH IS FOUND IN THE PALISAU
      IF ( IBUF (3, 1) . EQ.C.AND.IBUF (4,1) . EQ.A.AND.IBUF (5,1) . EQ.R.AND.
                                                                            PAL05570
          IBUF (6, 1) . EQ. R. AND . IBUF (7, 1) . EQ. Y ) IMATCH=99
                                                                            PAL06580
                                                                            PAL06590
      RETURN
      END
                                                                            PAL06600
```

FILE: PAL20

FORTRAN A

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FILE: PAL20 FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
```

```
c
                                                                         PAL06610
***PAL06620
                                                                         PAL06630
      SUBROUTINE IXLATE (IINPUT, IMATCH, LPHASE, LBUF, ITYPE)
                                                                         PAL06640
c
      THIS SUBROUTINE FINDS A MATCH BETWEEN THE INPUT PIN NUMBER AND
                                                                         PAL06650
С
       THE INPUT LINE NUMBER FOR A SPECIFIC PAL. ADD I TO THE INPUT
                                                                         PAL06660
c
       LINE NUMBER IF THE PIN IS A COMPLEMENT
                                                                         PAL06670
      IMPLICIT INTEGER (A-Z)
                                                                         PAL06680
      INTEGER ITABLE (20.6)
                                                                         PAL06690
      LOGICAL LPHASE (23), LBUF (20)
                                                                         PAL06700
              ITABLE/
                                                                         PAL06710
         3, 1, 5, 9, 13, 17, 21, 25, 29, -10, 31, -1, -1, -1, -1, -1, -1, -1, -1, -20,
                                                                         PAL06720
         3, 1, 5, 9, 13, 17, 21, 25, 29, -10, 31, 27, -1, -1, -1, -1, -1, -1, 7, -20,
                                                                         PAL06730
     - 3
         3, 1, 5, 9, 13, 17, 21, 25, 29, -10, 31, 27, 23, -1, -1, -1, -1, 11, 7, -20,
                                                                         PAL06740
     u
         3, 1, 5, 9, 13, 17, 21, 25, 29, -10, 31, 27, 23, 19, -1, -1, 15, 11, 7, -20,
                                                                         PAL06750
         3, 1, 5, 9, 13, 17, 21, 25, 29, -10, 31, -1, 27, 23, 19, 15, 11, 7, -1, -20,
     5
                                                                         PAL06760
       -1, 1, 5, 9, 13, 17, 21, 25, 29, -10, -1, 31, 27, 23, 19, 15, 11, 7, 3, -20/
                                                                         PAL06770
                                                                         PAL06780
     IINPUT=0
      1 3 UBL = 0
                                                                         PAL06790
     IF(((
                LPHASE (INATCH)) . AND. (. NOT. LBUF (1))) . OR.
                                                                         PAL06800
         ((.NOT.LPHASE(IMATCH)).AND.( LBUF(1)))) IBUBL=1
                                                                         PAL06810
     IF ( ITABLE (IMATCH, ITYPE) .GT.O ) IINPUT=ITABLE (IMATCH, ITYPE) + IBUBL PALO6820
      RETURN
                                                                         PAL06830
                                                                         PAL06840
C
                                                                         PAI.06850
C
                                                                         PAL06870
      SUBROUTINE FIXSYM(LBUF, LBUF, IC, IL, LFIRST, LFUSES, TBLOW, IPROD, LFIX)
                                                                         PAL06880
      THIS SUBROUTINE EVALUATES THE FIXED SYMBOLS FOUND IN THE
C
                                                                         PAL06890
С
       PAL16X4 AND PAL16A4
                                                                         PAL06900
      IMPLICIT INTEGER (A-Z)
                                                                         PAL06910
      LOGICAL LBUF (20), LFUSES (32,64), LFIRST, LMATCH, LFIX
                                                                         PAL06920
      INTEGER IBUF (8, 20), FIXBUF (8), TABLE (5, 14)
                                                                         PAL06930
      COMMON /PGE/ IPAGE(80, 200)
                                                                         PAL06940
      DATA A/'A'/, B/'B'/, ISLASH/'/'/, IOR/'+'/, IBLANK/' '/, IRIGHT/')'/,
                                                                         PAL06950
              IAND/***/,N/*N*/,Q/*Q*/,NO/*O*/,N1/*1*/,N2/*2*/,N3/*3*/,
                                                                         PAL06960
     2
            ICOLON/':'/.
                                                                         PAL06970
     3
                                ' ','A','+','/','B',' ',' ','A','+','B',PAL06980
             TABLE
     4
            1 1,1 1,1 1,1 1,1 1,1A1,1/1,1A1,1+1,1/1,1B1,1 1,1 1,1 1,1/1,1B1,PAL06990
            'A',':','+',':','B','','A','*','','B',''','A','+','B',PAL07010
     5
     b
            IINPUT=0
                                                                         PAL07030
      DO 20 I=1,6
                                                                         PAL07040
          IBUF (I, 1) = IBLANK
                                                                         PAL07050
          FIXBUF (I) = IBLANK
  20
                                                                         PAL07060
   21 CALL INCR (IC, IL, LFIX)
                                                                         PAL07070
     I=IPAGE(IC,IL)
                                                                         PAL07080
     IF (I.EQ. IRIGHT) GO TO 40
                                                                         PAL07090
     F(I,EQ.NO) IINPUT=8
                                                                         PAL07100
     IF (I.EQ.N1) IINPUT=12
                                                                         PAL07110
     IF (I, EQ, N2) IINPUT= 16
                                                                         PAL07120
     IF (I.EQ.N3) IINPUT=20
                                                                         PALO7130
      DO 24 J=1.7
                                                                         PALO7140
          IBUF(J, 1) = IBUF(J+1, 1)
                                                                         PALO 7150
```

```
IBUF (8, 1) = I
                                                                            PALO7160
      IF (.NOT. ( (1.20.A).Oh. (1.20.B).OR. (1.20.ISLASH).OR. (1.20.IOR)
                                                                            PALO7170
                                                                            PAL07180
             .OR. (I.EQ. IAND) .OR. (I.EQ. ICOLON) ) GO TO 21
      DO 30 I=1,4
                                                                            PALO7190
          FIXBUF(I) = FIXBUF(I+1)
                                                                            PAL07200
      FIXBUF (5) = IPAGE (IC, IL)
                                                                            PAL07210
      GO TO 21
                                                                            PAL07220
   40 IMATCH=U
                                                                            PAL07230
      DO 60 J=1,14
                                                                            PAL07240
          LMATCH=.TRUE.
                                                                            PA1.07250
          DO 50 1=1,5
                                                                            PAL07260
   50
               LMATCH=LMATCH .AND. ( FIXBUF(I).Ex.TABLE(I,J) )
                                                                            PAL07270
   60
          IF (LMATCH) IMATCH=J
                                                                            PAL07280
      IF (IMATCH. EQ. 0) GG TO 100
                                                                            PAL07290
      IF (.NOT. LFIRST) GO TO 35
                                                                            PAL07300
          LFIRST= . FALSE.
                                                                            PAL07310
          DO 80 I=1,32
                                                                            PAL07320
               LFUSES (I, 1PROD) = TRUE.
                                                                            PALO7330
   ü C
               ISLOW = IBLOW + 1
                                                                            PAL07346
   35 DO 90 1=1.4
                                                                            PAL07350
          IF ( (IMATCH-7) . LE. 0 ) GO TO SU
                                                                            PALO 7360
          ISUM != IINPUT + I
                                                                            PAL07370
          LFUSES (ISUAL, IPROD) = . FALSE.
                                                                            PAL07383
          IBLOW = IBLOW - 1
                                                                            PAL07390
          IMATCH=IMATCH-8
                                                                            PAL07400
   30 IMATCH=IMATCH+IMATCH
                                                                            PAL07410
      LBUF (1) = . TRUE.
                                                                            PAL07420
      CALL PLOT (LBUF, IBUF, LFUSES, IPROD, TITLE, .FALSE., ITYPE,
                                                                            PALO7430
                 LPROD, IOP, IBLOW, IPCTR)
                                                                            PALOT440
  100 LFIX=.FALSE.
                                                                            PAL07450
      CALL INCR (IC, IL, LFIX)
                                                                            PAL07460
      RECHEN
                                                                            2AL07470
      END
                                                                            PAL07480
C
                                                                            PAL07490
С
                                                                            PAL07510
      SUBROUTINE ECHO (IPAL, INOAI, IOT, INOO, REST, PATNUM, TITLE, COMP)
                                                                            PAL07520
C
      THIS SUBROUTINE PRINTS THE PAL DESIGN SPECIFICATION INPUT FILE
                                                                            PAL07530
      IMPLICIT INTEGER (A-Z)
                                                                            PAL07540
      INTEGER IPAL (4), REST (73), PATNUM (60), TITLE (80), COMP (80)
                                                                            PAL07550
      COMMON /PGE/ IPAGE(80, 200)
                                                                            PALU7560
      COMMON /LUNIT/ PMS, POF, PDF
                                                                            PAL07570
      COMMON /FREST/ 1FUNCT, IDESC, 1END
                                                                            PAL07580
      DATA IBLANK/ 1/
                                                                            PAL07590
      WRITE (POF, 5) IPAL, INOAL, IOT, INOO, REST, PATNUM, TITLE, COMP
                                                                            PAL07600
    5 FORMAT(/,' ',4A1,A1,A1,A1,73A1,/,' ',80A1,/,' ',80A1,/,' ',80A1)
                                                                            PAL07610
      DO 20 IL=1. IEND
                                                                            PAL07620
           IC=31
                                                                            PAL07630
   10
           IC=1C-1
                                                                            PAL07640
           IF ( IPAGE (IC, IL), EQ, IBLANK, AND, IC, GT, 1 ) GO TO 10
                                                                            PAL07650
           WRITE (POF, 15) (IPAGE (I, IL), I= 1, IC)
                                                                            PAL07660
   15
           FURMAT ( ' . BOA I)
                                                                            PAL07670
   20 CONTINUE
                                                                            PAL07680
      BETURN
                                                                            PAL07690
```

NSC TIME SHARING SERVICES VM/SP RELEASE 2.0

FILE: PAL20

END

FORTRAN A

FILE: PAL20

FORTRAN

IIN(3,2) = INOAI

```
C
                                                                       PAL07710
C
                                                                       PAL07730
     SUBROUTINE CAT
                                                                       PAL07740
     THIS SUBROUTINE PRINTS THE PALASM CATOLOG
                                                                       PAL07750
     IMPLICIT INTEGER (A-Z)
                                                                       PALO7760
     COMMON /LUNIT/ PMS, POF, PDF
                                                                       PAL07770
     WRITE (PMS, 10)
                                                                       PALO7780
   10 FORMAT(/, THIS PALASM AIDS THE USER IN THE DESIGN AND,
                                                                       PAL07790
              ' PROGRAMMING OF THE',/,' SERIES 20 PAL FAMILY. THE',
     1
                                                                       PAL07800
              * FOLLOWING OPTIONS ARE PROVIDED: 1,
                                                                       PAL07810
     3
                                - PRINTS THE PAL DESIGN',
                                                                       PAL07820
                    ECHO (E)
                SPECIFICATION',
     4
                                                                       PAL07830
                                - PRINTS THE PINOUT OF THE PAL!,
    5
           //.
                   PINOUT (O)
                                                                       PAL07840
           11.1
                    SIMULATE (T) - EXERCISES THE FUNCTION TABLE .
                                                                       PALO 7850
                                                                       PAL07860
    7
                VECTORS IN THE LOGIC',/,'
     8
                EQUATIONS AND GENERATES TEST VECTORS',
                                                                       PAL07870
     9
           11.
                                - PRINTS THE ENTIRE FUSE PLOT!)
                                                                       PAL07880
                    PLOT (P)
     WRITE (PMS, 20)
                                                                       PAL07890
   20 FORMAT (/,'
                                - PRINTS ONLY THE USED PRODUCT LINES', PALO7900
                   BRIEF (B)
                OF THE FUSE PLOT',/,'
     1
                                                        PHANTOM',
                                                                       PAL07910
     2
                FUSES ARE OMITTED'.
                                                                       PAL07920
           //,1
    3
                                - GENERATES HEX PROGRAMMING FORMAT',
                   HEX (H)
                                                                       PAL07930
           11.1
    4
                   SHORT (S)
                                - GENERATES HEX PROGRAMMING FORMAT',
                                                                       PALO 7940
           //.
    5
                   BHLF (L)
                                - GENERATES BHLF PROGRAMMING FORMAT .
                                                                       PAL07950
           //,1
    h
                   BNPF (N)
                                - GENERATES BNPF PROGRAMMING FORMAT .
                                                                       PAL07960
           //,1
     7
                   CATALOG (C) - PRINTS THE PALASM CATALOG',
                                                                       PAL07970
           //,
    ö
                                - EXIT PALASM',
                   QUIT (2)
                                                                       PAL07980
           //,'
    9
                   JEDEC (Y)
                                - JEDEC FORMAT FOR DATA I/O PROGRAMMER'PALO7990
     A
                   FAULT (F)
                                                                       PAL08000
                                - FAULT TESTING ')
     RETURN
                                                                       PAL08010
     END
                                                                       PAL08020
c
                                                                       PAL08030
PAL08050
                                                                       PAL08060
     SUBROUTINE PINOUT (IPAL, INDAI, IOT, INDO, TITLE)
     THIS SUBBOUTINE PRINTS THE PINOUT OF THE PAL
C
                                                                       PAL08070
     IMPLICIT INTEGER (A-Z)
                                                                       PAL08080
     INTEGER IPAL (4), TITLE (80), PIN (12, 20), IIN (7, 2)
                                                                       PAL08090
     COMMON /PGE/ IPAGE (80, 200)
                                                                       PAL08 100
     COMMON /LUNIT/ PMS, POF, PDF
                                                                       PAL08110
     DATA IBLANK/ 1/, ISTAR/ **/
                                                                       PAL08120
     DO 10 J=1,20
                                                                       PAL08 130
         DO 5 I=1,12
                                                                       PAL08140
             PIN(I, J) = IBLANK
                                                                       PAL08150
   10 CONTINUE
                                                                       PAL08160
   15 DO 25 J=1,2
                                                                       PALO8 170
         DO 20 I=1.7
                                                                       PAL08180
  20
             IIN (I, J) = IBLANK
                                                                       PAL08190
  25 CONTINUE
                                                                       PAL08200
     IIN(2,1) = IPAL(1)
                                                                       PAL08210
     IIN(4,1) = IPAL(2)
                                                                       PAL08220
     IIN(6,1) = IPAL(3)
                                                                       PAL08230
     IIN(1,2) = IPAL(4)
                                                                       PAL08240
```

NSC TIME SHARING SERVICES VM/SP RELEASE 2.0

```
FILE: PAL20
                 FORTRAN
                               NSC TIME SHARING SERVICES VM/SP'RELEASE 2.0
      IIN(5,2) = IOT
                                                                                 2AL08260
      IIN(7,2) = INOO
                                                                                 PAL08270
      J = 0
                                                                                 PAL08280
      IL=0
                                                                                 PAL08290
   30 IC=0
                                                                                 PALOB300
      IL=IL+1
                                                                                 PAL08310
   35 IC=1C+1
                                                                                 PAL08326
   40 IF( IC.GT.80 ) GO TO 30
                                                                                 PAL08330
                                                                                 PAL08340
      IF ( IPAGE (IC, IL) . EQ. IBLANK ) GO TO 35
                                                                                 PAL08350
      J=J+1
      IF(J.GT.20) GO TO 60
                                                                                 PAL08360
      DO 55 I=1,12
                                                                                 PAL08376
           PIN(I,J) = IPAGE(IC,IL)
                                                                                 DALOB380
           IC=IC+1
                                                                                 PAL08390
           IF( IC.GT.80 ) GO TO 46
                                                                                 PAL08400
           IF ( IPAGE (IC, IL) . EQ. IBLANK ) GO TO 40
                                                                                 PAL08410
   55 CONTINUE
                                                                                 PAL08426
   60 DO 75 J=1.10
                                                                                 PAL08430
           II = 0
                                                                                 PALO8440
   65
           II=II+1
                                                                                 PAL08450
           IF(II.E2.13) GO TO 75
                                                                                 PAL08460
           IF ( PIN (II, J) . NE, I BLANK ) GO TO 65
                                                                                 PALUB470
           1 = 13
                                                                                 PAL08480
   70
           I = I - 1
                                                                                 PAL08490
           II=II-1
                                                                                 PALO8500
           PIN(I,J) = PIN(II,J)
                                                                                 PAL08510
           PIN(II.J) = IBLANK
                                                                                 PAL08520
           IF(II, NE. 1) GG TO 70
                                                                                 PALOB530
   75 CONTINUE
                                                                                 PAL08540
      WRITE (POF, 76) TITLE
                                                                                 PAL08550
   76 FORMAT (/, 1 1,80A1)
                                                                                 PAL08560
      WRITE (POF, 70) ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                                                                                 PAL08576
                      ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                                                                                 PAL08580
     2
                      ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                                                                                 PAL08590
                      ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR
                                                                                 PALOS600
   78 FORMAT(/, ' ', 18x, 14A1, 3x, 14A1,
                                                                                 PAL08610
     1
              /, ' ', 13x, A1, 13x, A1, 1x, A1, 13x, A1)
                                                                                 PALU3620
      JJ = 20
                                                                                 PALOBGIO
      DO 88 J=1,10
                                                                                 PAL08640
           WRITE (POF, 80) ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, PALO 8650
   30
           FORMAT (' ', 15x, 4A1, 29x, 4A1)
                                                                                 PAL08660
           WRITE (POF, 81) (PIN(I,J), I=1,12), ISTAR, J, ISTAR,
                                                                                 PAL08670
                 (IIN(I,1),I=1,7),ISTAR,JJ,ISTAR,(PIN(I,JJ),I=1,12)
                                                                                 PAL08680
   81
           FORMAT( 1, 12A1, 3x, A1, I2, A1, 11x, 7A1, 11x, A1, I2, A1, 3x, 12A1)
                                                                                 PAL08690
           WRITE (POF, 62) ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR PALO8700
           FORMAT (1 1, 15x, 4A1, 29x, 4A1)
   82
                                                                                 PAL08710
           write (POF, 34) ISTAR, (IIN (1,2), I=1,7), ISTAR
                                                                                 PALOS720
   84
           FORMAT (' ', 18x, A1, 11x, 7A1, 11x, A1)
                                                                                 PAL08730
           DO 86 II=1,2
                                                                                 PAL08740
               DO 85 I=1.7
                                                                                 FALO8753
   85
                    IIN (I, II) = IBLANK
                                                                                 PAL08760
   86
           CONTINUE
                                                                                 PAL08770
           JJ=JJ-1
                                                                                 PAL08780
                                                                                 PAL08790
      WRITE (POF, 90) ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                                                                                 COSSOIAG
```

```
FILE: PAL20
                FORTRAN
                              NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
     1
                     ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                                                                             PALOSSIO
     2
                     ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                                                                             PALOSSZU
                                                                             PAL08830
                     ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR
   90 FORMAT(' ', 18X, 31A1)
                                                                             PAL08840
      RETURN
                                                                             PAL08850
                                                                             PAL08860
      END
                                                                             PAL08870
C
PAL08890
С
                                                                             PAL08900
      SUBROUTINE PLOT (LBUF, IBUF, LFUSES, IPROD, TITLE, LDUMP, ITYPE,
                       LPROD, IOP, IBLOW, IPCTRO)
                                                                             PAL08910
     1
      THIS THIS SUBROUTINE PRODUCES THE FUSE PLOT
                                                                             PAL08920
С
      IMPLICIT INTEGER (A-Z)
                                                                             PAL08930
      INTEGER 180F (8, 20), IOUT (64), ISAVE (64, 32), TITLE (80)
                                                                             PAL08940
      LOGICAL LBUF (20), LFUSES (32,64), LDUMP, LPROD (80)
                                                                             PAL08950
      COMMON /LUNIT/ PMS, POF, PDF
                                                                             PAL08960
      DATA ISAVE/2048* 1/, IAND/ 141/, IOR/ 1+1/, ISLASH/ 1/1/,
                                                                             PAL08970
           IDASH/'-'/, X/'X'/, IBLXNK/' '/, P/'P'/, B/'B'/,
                                                                             PAL08980
           HIFANT/'O'/
                                                                             PAL08990
     2
      IF (LDUMP) GO TO 60
                                                                             PAL09000
                                                                             PAL09010
    IF (ISAVE (IPROD, 1) . NE. IBLANK) RETURN
                                                                             PAL09020
      IF( LBUF(1) ) GO TO 5
      DO 30 J=1,31
                                                                             PAL09030
   30
          ISAVE (IPROD. J) = ISAVE (IPROD. J+1)
                                                                             PAL09040
      ISAVE (IPROD, 32) = ISLASH
                                                                             PAL09050
    5 DO 20 I=1,8
                                                                             PAL09060
         IF ( ISAVE (IPROD. 1) . NE. IBLANK ) RETURN
                                                                             PAL09070
          IF ( IBUF (I, 1) . EQ. IBLANK ) GO TO 20
                                                                             PAL09080
          00 \ 10 \ J=1,31
                                                                             PAL09090
   10
               ISAVE (IPROD, J) = ISAVE (IPROD, J+1)
                                                                             PAL09100
          ISAVE (IPROD. 32) = IBUF (I. 1)
                                                                             PAL09110
   20
                                                                             PAL03120
          CONTINUE
      IF (ISAVE (IPROD, 1) . NE. IBLANK) RETURN
                                                                             PAL09130
   40 DO 50 J=1,31
                                                                             PAL09140
                                                                             PAL09150
  . 50
          ISAVE (IPROD, J) = ISAVE (IPROD, J+1)
      ISAVE (IPROD, 32) = IAND
                                                                             PAL09160
      RETURN
                                                                             PAL09170
      PRINT FUSE PLOT
                                                                             PAL09180
   60 WRITE (POF, 62) TITLE
                                                                             PAL09190
   62 FORMAT (/, 1 1,80A1,//,
                                                                             PAL09200
                          11 1111 1111 2222 2222 2233',/,
   . [ 1
                                                                             PAL09210
     2 . 1
            0123 4567 8901 2345 6789 0123 4567 89011,/)
                                                                             PAL09220
      DO 100 I88PRO=1,57,8
                                                                             PAL09230
          DO 94 I8PRO=1,8
                                                                             PAL09240
               IPROD=188PRO+18PRO-1
                                                                             PAL09250
               ISAVE (IPROD, 32) = IBLANK
                                                                             PAL09260
               00 70 I=1.32
                                                                             PAL09270
                   IF ( ISAVE (IPROD, 1) . NE. IBLANK ) GO TO 70
                                                                             PAL09280
                   DO 65 J=1,31
                                                                             PAL09290
                       ISAVE (IPROD, J) = ISAVE (IPROD, J+1)
                                                                             PAL09300
   65
                       CONTINUE
                                                                             PAL09310
                   ISAVE (IPROD, 32) = IBLANK
                                                                             PAL09320
   70
              CONTINUE
                                                                             PAL09330
               DO 80 I=1.32
                                                                             PAL09340
                  IOUT (I) = X
                                                                             PAL09350
```

```
FILE: PAL20
                FORTRAN A
                             NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
                    IF ( LEUSES (I, IPROD) ) IOUT (I) = IDASH
                                                                               PALO J 360
                    10UT (1+32) = ISAVE (IPROD. 1)
                                                                               PAL09370
   80
               CONTINUE
                                                                               PAL09380
               IF (ITYPE, LE, 4) CALL FARTOM (ITYPE, IOUT, IPROD, ISPRO)
                                                                               PAL03390
               IPROD=IPROD-I
                                                                               PAL09400
               30 85 J=1.32
                                                                               PAL09410
                    IF ( IOP.EQ.B.AND.IOJT(J).EQ.HIFANT ) IOUT(J) = IBLANK
                                                                               PAL09420
                                                                               PAL09430
               IF ((IOP, EQ, P), OR, (IOP, EQ, B, AND, (LPROD(IPROD+1))))
                                                                               PAL09440
               WRITE (POF, 90) IPHOD, IOUT
                                                                               PAL0 3450
   40
               FORMAT (1 1, 12, 5 (1 1, 4 A 1), 1 1, 3 2 A 1)
                                                                               PAL09460
   94
               CONTINUE
                                                                               PAL09470
           HAITE (POF, 96)
                                                                               PAL09480
   96
           FORMAT (1X)
                                                                               PAL09490
  100
          CONTINUE
                                                                               PAL095GU
      WRITE (POF, 110)
                                                                               PALOSSIU
  110 FORMAT(/,
                                                                               PAL09520
     1º LEGENO: X : FUSE NOT BLOWN (L,N,0) - : FUSE BLOWN
                                                                     (n.P.1) ') PALG9530
      IF ( IOP, EQ. P. AND, ITYPE, LE.4 ) WRITE (POF, 111)
                                                                               PAL09540
  111 FORMAT (
                                                                               PAL03550
     1 *
                   U : PHANTOM FUSE
                                        (L, N, 0) O: PHANTOM FUSE (H, P, 1) 1) PALO 9560
      WRITE (POF, 112) IBLOW
                                                                               PAL09570
  112 FORMAT (/, NUMBER OF FUSES BLOWN = 1,14)
                                                                               PAL09580
      RETURN
                                                                               PALO 3590
      END
                                                                               00360149
                                                                               PAL09610
C***********************************
C
                                                                               PALOGERA
      SUBROUTING HEX (LFUSES, TOP)
                                                                               PAL09640
      THIS SUBROUTINE GENERATES HEX PROGRAMMING FORMATS
                                                                               PAL09650
     · IMPLICIT INTEGER (A-Z)
                                                                               PAL09660
      INTEGER ATABLE (10), ITEMP (64), 2CSUM (4)
                                                                               PAL09670
      LOGICAL LEUSES (32,64)
                                                                               PA1.0968u
      INTEGER
                 SOH, STX, ETX, BEL
                                                                               PAL03690
      COMMON /LUNIT/ PMS.20F.PDF
                                                                               PAL03703
      DATA H/'d'/,S/'S'/,TBLANK/' '/,
ZTABLE/'0','1','2','3','4','5','6','7',
'8','9','A','6','C','b','E','F'/
                                                                               PAL03713
                                                                               PAL09720
     2
                                                                               PAL09730
      DATA SOH /201000000/ , STX /202000000/ ,
                                                                               PAL09740
                 ETX/203000000/ . BEL /20700000/
                                                                               PALO 1750
      CSUM=0
                                                                               PAL09760
      IF (IOP, Eg. H) WRITE (PDF, 10)
                                                                               PAL09770
   10 FORMAT (//, 1
                                                                               PAL09780
C**** NOTE: SOME PROM PROGRAMMERS NEED A START CHARACTER.
                                                                               PAL09790
C * * * * *
              THIS PROGRAM OUTPUTS AN STX FOR THE DATA I/O MODEL 9
                                                                               PAL09800
C * * * * *
                (USE SOH FOR MODEL 5)
                                                                               PAL09810
      WRITE (PDF, 5) BEL, BEL, BEL, BEL, BEL, BEL, STX, SOH
                                                                               PAL09820
    5 FORMAT (' 1,9A1)
                                                                               PAL09830
    DO 40 I=1,33,32
                                                                               PAL09840
      INC = I - I
                                                                               PAL09850
        DO 40 IPROD=1,7,2
                                                                               PAL09860
          00 20 J=1,2
                                                                               PAL09870
               00 20 IINFUT=1,32
                                                                               PAL09880
               1 \text{ HeX} = 0
                                                                               PAL09890
               ISUM2=IPROD + J-1 + INC
                                                                               PAL09900
```

```
FILE: PAL20
                FORTRAN
                               NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
               IF (LFUSES (IINPUT, ISUM2 + 0 )) IHEX=IHEX+1
                                                                               PAL09910
               IF (LFUSES (IINPUT, ISUM2 + 8 )) IHEX=IHEX+2
                                                                               PAL09920
               IF (LFUSES (IINPUT, ISUM2 + 16 )) IHEX=IHEX+4
                                                                               PAL09930
               IF (LFUSES (IINPUT, ISUM2 + 24 )) IHEX=IHEX+8
                                                                               PAL09940
               CSUM=CSUM+IHEX
                                                                               PAL09950
               ISUMX=IINPUT+(32*(J-1))
                                                                               PAL09960
   20
               ITEMP (ISUMX) = ZTABLE (IHEX+1)
                                                                               PAL09970
          IF (IOP.EQ.H) WRITE (PDF, 30) ITEMP
                                                                               PAL09980
           FORMAT(' ',32(A1,' '),',',/,' ',32(A1,' '),',')
   30
                                                                               PAL09990
   40
           IF (IOP.EQ.S) WRITE (PDF.50) ITEMP
                                                                               PAL 10000
           FORMAT ( ' ',64A1)
   50
                                                                               PAL10010
      IF (IOP.EQ.H) WRITE (PDF. 70)
                                                                               PAL 10020
   70 FORMAT (' ',//,'
                                                                  . 1.//)
                                                                               PAL 10030
      WRITE (PDF, 80) ETX
                                                                               PAL 10040
   80 FORMAT (' ', A1)
                                                                               PAL10050
С
      CONVERT DECIMAL CHECK SUM INTO HEX CHECK SUM
                                                                               PAL 10060
      DO 85 I=1.4
                                                                               PAL 10070
            2TEMP=CSUM-16* (CSUM/16)
                                                                               PAL 10080
            ZCSUM (5-1) = ZTABLE (ZTEMP+1)
                                                                               PAL 10090
            CSUM=CSUM/16
                                                                               PAL 10100
   85 CONTINUE
                                                                               PAL 10 110
      IF (ZCSUM(1).EQ.ZTABLE(1)) ZCSUM(1) = IBLANK
                                                                               PAL 10 120
      WRITE (PMS, 90) ZCSUM (1), ZCSUM (2), ZCSUM (3), ZCSUM (4)
                                                                               PAL 10130
   90 FORMAT (/ HEX CHECK SUM = 1,4A1)
                                                                               PAL 10 140
      RETURN
                                                                               PAL 10 150
      END
                                                                               PAL 10 160
c
                                                                               PAL 10 170
C********************************
                                                                           ****PAL10180
c
                                                                               PAL10190
      SUBROUTINE TWEEK (ITYPE, IOT, LFUSES)
                                                                               PAL 10 200
С
      THIS SUBROUTINE TWEEKS LFUSES (THE PROGRAMMING FUSE PLOT)
                                                                               PAL10210
C
       FOR HIGH AND LOW PHANTOM FUSES
                                                                               PAL10226
      IMPLICIT INTEGER (A-Z)
                                                                               PAL 10 230
      LOGICAL LFUSES (32,64)
                                                                               PAL 10240
      DATA L/'L'/, C/'C'/
                                                                               PAL10250
      IF (ITYPE, GE. 4) GO TO 20
                                                                               PAL 10260
      DO 10 IPROD=1,64
                                                                               PAL 10270
           LFUSES (15, IPROD) = . TRUE.
                                                                               PAL 10280
           LFUSES (16. IPROD) = . TRUE.
                                                                               PAL 10290
           LFUSES (19, IPROD) = . TRUE.
                                                                               PAL10300
           LFUSES (20, IPROD) = . TRUE.
                                                                               PAL 10310
           IF(ITYPE,GE,3) GO TO 10
                                                                               PAL 10320
           LFUSES (11, IPROD) = . TRUE.
                                                                               PAL10330
           LFUSES (12, IPROD) = .TRUE.
                                                                               PAL 10340
           LFUSES (23, IPROD) = .TRUE.
                                                                               PAL 10350
          LFUSES (24, IPROD) = . TRUE.
                                                                               PAL10360
                                                                               PAL 10370
           IF(ITYPE.GE.2) GO TO 10
           LFUSES ( 7, IPROD) = TRUE.
                                                                               PAL10380
           LFUSES ( 8, IPROD) = .TRUE.
                                                                               PAL 10390
           LFUSES (27, IPROD) = .TRUE.
                                                                               PAL 10400
           LFUSES (28, IPROD) = . TRUE.
                                                                               PALICAIN
   10
          CONTINUE
                                                                                PAL10420
     DO 18 IINPUT=7,28
                                                                                PAL 10430
          DO 12 IPROD=1,57,8
                                                                               PAL 10446
                                                                               PAL 10450
               LFUSES (IINPUT, IPROD+4) = . FALSE.
```

```
FILE: PALZO
                FORTRAN
                              NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
               LFUSES (IINPUT, IPROD+5) = . FALSE.
                                                                             PAL 10460
               LFUSES (IINPUT, IPROD+6) = . FALSE.
                                                                             PAL10470
               LFUSES (IINPUT, IPROD + 7) = . FALSE.
                                                                             PAL10480
   12
                                                                             PAL 10490
          IF(ITYPE.GE.3) GO TO 18
          DO 14 IPROD=17,41,8
                                                                             PAL 10500
               LFUSES (IINPUT, IPROD+2) = . FALSE.
                                                                             PAL 10510
   14
               LFUSES (IINPUT, IPROD+3) = . FALSE.
                                                                             PAL10520
           IF (ITYPE.GE. 2) GO TO 18
                                                                             PAL 10530
          DO 16 IPAOD=1,57,8
                                                                             PAL 10540
               LFUSES (IINPUT, IPROD + 2) = . FALSE.
                                                                             PAL10550
               LFUSES (IINPUT, IPROD+3) = FALSE.
                                                                             PAL 10560
   16
   18 CONTINUE
                                                                             PAL 10570
                                                                             PAL10580
   26 IF ( (ITYPE.EQ.1) .OR. ((ITYPE.EQ.4).AND. (IOT.EQ.L)) ) RETURN
      DO 99 IINPUT=1,32
                                                                             PAL 10590
          DO 30 IPROD=1,8
                                                                             PAL 10600
               LFUSES (IINPUT, 1PROD + 0) = (IOT, NE.L)
                                                                             PAL 10610
   30
               IF (IOT.NE.C) LFUSES (IINPUT, IPROD+56) = (IOT.NE.L)
                                                                             PAL10620
          IF (ITYPE, LE. 2) GO TO 99
                                                                             PAL 10630
          DO 40 IPROD=1,8
                                                                             PAL10640
               LFUSES (IINPUT, IPROD + 8) = (IOT.NE.L)
                                                                             PAL 10650
   40
               IF (IOT.NE.C) LFUSES (IINPUT, IPROD + 48) = (IOT.NE.L)
                                                                             PAL10660
                                                                             PAL10670
          IF (ITYPE.LE.3) GO TO 99
          DO 50 12ROD=1,8
                                                                             PAL10680
               LFUSES (IINPUT. IPROD+16) = (IOT.NE.L)
                                                                             PAL 10690
               IF (IOT.NE.C) LEUSES (IINPUT, IPROD+40) = (IOT.NE.L)
                                                                             PAL10700
   50
   99
          CONTINUE
                                                                             2AL10710
      RETURN
                                                                             PAL 10720
      END
                                                                             PAL 1.3730
¢
                                                                             PAL 10740
С
                                                                             PAL 10760
      SUBROUTINE BINR (LFUSES, H, L)
                                                                             PAL 10770
C
      THIS SUBROUTINE GENERATES BINARY PROGRAMMING FORMATS
                                                                             PAL10780
      IMPLICIT INTEGER (A-Z)
                                                                             PAL 10790
                                                                             COSCILAG
      INTEGER ITEMP (4,8)
      LOGICAL LFUSES (32,64)
                                                                             PAL10810
      CONMON /LUNIT/ PMS, POF, PDF
                                                                             PAL 10820
                                                                             PAL 10830
      WRITE (PDF. 10)
   10 FORMAT (//, 1
                                                                             PAL 10840
                                                              .'.//)
      DO 20 I=1,33,32
                                                                             PAI 10850
      INC=I-1
                                                                             PAL 10860
        DO 20 1PROD=1,8
                                                                             PAL 10870
             DO 20 J=1,25,8
                                                                             PAL 10880
               DO 15 K=1,8
                                                                             PAL10890
                 IINPUT=J+K-1
                                                                             PAL 10900
                 ITEMP (1, K) = L
                                                                             PAL 10910
                 ITEMP (2,K)=L
                                                                             PAL 10920
                 ITEMP (3,K)=L
                                                                             PAL 10930
                 ITEMP (4,K)=L
                                                                             PAL 10940
                 ISUM 3=IPROD+INC
                                                                             PAL 10950
                 IF (LFUSES (IINPUT, ISUN3 + 0 )) ITEMP (4, K) = H
                                                                             PAL 10960
                 IF (LFUSES (IINPUT, ISUN3 + 3)) ITEMP (3, K) = 3
                                                                             PAL 10970
                 IF (LFUSES (IINPUT, ISUM3 + 16 )) ITEMP (2, K) = H
                                                                             PAL 10980
                 IF (LFUSES (IINPUT. ISUM3 + 24 )) ITEMP (1.K) =H
                                                                             PAL 10990
   15
                 CONTINUE
                                                                             PAL 11000
```

```
FILE: PAL20
                              NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
                FORTRAN
               WRITE (PDF, 30) ITEMP
   20
                                                                               PAL 11010
   30
               FORMAT (' ', 8 ('B', 4A1, 'F '))
                                                                               PAL 11020
      WRITE (PDF, 10)
                                                                               PAL 11030
      RETURN
                                                                               PAL 11040
      END
                                                                               PAL 11050
c
                                                                               PAL 11060
C***********
                                                                         *****PA1.11070
С
                                                                               PAL 11080
      SUBROUTINE SLIP (LFUSES, 188PRO, INOAT, TOT, INOO, IBLOW)
                                                                               PAL 11090
C
      THIS SUBROUTINE WILL BLOW THE ENTIRE CONDITIONAL THREE-STATE
                                                                               PAL 11100
C
       PRODUCT LINE WHEN 'IF (VCC)' CONDITION IS USED FOR THE
                                                                               PAL 11110
C
       CORRESPONDING OUTPUT PIN
                                                                               PAL 11120
      IMPLICIT INTEGER (A-Z)
                                                                               PAL 11130
      LOGICAL LFUSES (32,64)
                                                                               PAL 11140
      DATA R/'R'/, I1/'1'/, I2/'2'/, I4/'4'/, 16/'6'/, 18/'8'/
                                                                               PAL 11150
      IF ( (INOAI, NE, 16) .OR, (INOO, EQ. 11) .OR. (INOO, EQ. 12) .OR.
                                                                               PAL 11160
           ( (IOT.EQ.R) .AND. (INOO.EQ.18) ) .OR.
                                                                              PAL 11170
           ( (188PRO.GE, 9) .AND. (188PRO.LE.49) .AND. (INOO.EQ.16) .) .OR.
                                                                               PAL 11180
           ( (188PRO.GE.17).AND.(188PRO.LE.41).AND.(INOO.EQ.14)) ) RETURNPAL11190
      DO 10 \cdot I = 1,32
                                                                               PAL 11200
      IBLOW = IBLOW + 1
                                                                               PAL 11210
   10 LFUSES (I, 188PRO) = .TRUE.
                                                                               PAL 11220
      188PRO = 188PRO + 1
                                                                               PAL 11230
      RETURN
                                                                               PAL 11240
      END
                                                                               PAL 11250
С
                                                                               PAL11260
C**
                                                                        ******PAL11270
C
                                                                               PAL11280
      SUBROUTINE FANTOM (ITYPE, IOUT, IPHOD, 18PRO)
                                                                               PAL11290
С
      THIS SUBROUTINE UPDATES IOUT (THE PRINTED FUSE PLOT)
                                                                               PAL 11300
C
       FOR HIGH AND LOW PHANTOM FUSES
                                                                               PAL 11310
      IMPLICIT INTEGER (A-Z)
                                                                              PAL 11320
      INTEGER IOUT (64)
                                                                               PAL 11330
      DATA X/'X'/, IDASH/'-'/, LOFANT/'0'/, HIFANT/'0'/
                                                                               PAL 11340
      DO 10 I=1.32
                                                                               PAL 11350
           IF ( IOUT (I), EQ, IDASH ) IOUT (I) = HIFANT
                                                                               PAL11360
                                                                               PAL11370
           IF ( IOUT (I) .EQ.X )
                                    IOUT (I) = LOFANT
   10 CONTINUE
                                                                               PAL 11380
      IF ((ITYPE, EQ. 4).AND. ((IPROD. LE. 24). OR. (IPROD. GE. 41))) RETURN
                                                                               PAL11390
      IF ((ITYPE.EQ.3).AND. ((IPROD.LE.16).QR. (IPROD.GE.45))) RETURN
                                                                               PAL 11400
      IF ((ITYPE, EQ. 2) .AND. ((IPROD.LE. 8) .OR. (IPROD.GE.53))) RETURN
                                                                               PAL 11410
                                                                               PAL11420
      IF ((ITYPE.LE.3).AND. (I8PRO.GE.5)) RETURN
      IF ((ITYPE, LE, 2), AND, (IPROD, GE, 19), AND, (IPROD, LE, 48), AND,
                                                                               PAL 11430
          (ISPRO.GE.3)) RETURN
                                                                               PAL 11440
      IF ((ITYPE, EQ. 1) . AND. (I8PRO, GE. 3)) RETURN
                                                                               PAL 11450
      DO 50 I=1.32
                                                                               PAL11460
        IF ((I.EQ.15),OR,(I.EQ.16),OR,(I.EQ.19),OR,(I.EQ.20)). AND.
                                                                               PAL 11470
          (ITYPE, LE, 3)) GO TO 50
                                                                               PAL 11480
        IF (((I.EQ. 11).OR. (I.EQ. 12).OR. (I.EQ. 23).OR. (I.EQ. 24)).AND.
                                                                               PAL 11490
     1
                                                                               PAL 11500
          (ITYPE, LE, 2)) GO TO 50
                                                                               PAL 11510
        IF(((I.EQ. 7).OR.(I.EQ. 8).OR.(I.EQ.27).OR.(I.EQ.28)).AND.
          (ITYPE, LE, 1)) GO TO 50
                                                                               PAL 11520
                                                                               PAL11530
        IF ( IOUT (I) . EQ. HIFANT ) IOUT (I) = IDASH
                                                                               PAL 11540
        IF ( IOUT (I) .EQ. LOFANT ) IOUT (I) =X
   50 CONTINUE
                                                                              PAL 11550
```

```
FILE: PAL20
                   FORTRAN
                               NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
          RETURN
                                                                           PAL 11560
          END
                                                                           PAL 11570
                                                                           PAL11580
    C
                                                                           PAL 11600
          SUBROUTINE IODC2
                                                                           PAL 11610
    C**** THIS ROUTINE IS OPTIONAL, IT MAY BE USED TO TURN PERIPHERALS ON
                                                                          PAL11620
                                                                           PAL 11630
          IMPLICIT INTEGER (A-Z)
          INTEGER
                   BEL, DC2, ESC, FF, NUL
                                                                           PAL11640
          CONHON /LUNIT/ PMS, POF, PDF
                                                                           PAL 11650
          DATA BEL /207000000/ , DC2 /222000000/
                                                                           PAL 11660
          WRITE (PDF, 10) DC2, BEL
                                                                           PAL11670
       10 FORMAT (' ', 2A1)
                                                                           PAL 11680
          RETURN
                                                                           PAL 11690
                                                                           PAL 11700
          END
                                                                           PAL 11710
    PAL11730
         SUBROUTINE IODC4
                                                                           PAL 11740
    C***** THIS ROUTINE IS OPTIONAL, IT MAY BE USED TO TURN PERIPHERALS OFF PAL11750
          IMPLICIT INTEGER (A-Z)
                                                                           PAL11760
                   BEL, DC3, DC4
                                                                           PAL11770
          INTEGER
          COMMON /LUNIT/ PMS, POF, PDF
                                                                           PAL 11780
          DATA BEL/207000000/, DC3/223000000/, DC4/224000000/
                                                                           PAL 11790
          WRITE (PDF, 10) BEL, DC3, DC4
                                                                           PAL 11800
       10 FORMAT (1 1, 3A1)
                                                                           PAL 11810
          RETURN
                                                                           PAL 11820
          END
                                                                           PAL 11830
                                                                           PAL 11840
    С
                                                                           PAL 11860
          SUBROUTINE TEST (LPHASE, LBUF, TITLE, IC, IL, ILE, ISYM, IBUF, ITYPE,
                                                                           PAL 11870
                          INOO, LFIX, IPCTR, LERR, ISAF, IPCTR1, LSA11, LSA01)
                                                                           PAL 11880
   C
          THIS SUBROUTINE PERFORMS THE FUNCTION TABLE SIMULATION
                                                                           PAL11890
   C
           AND GENERATES TEST VECTORS
                                                                           PAL 11900
          IMPLICIT INTEGER (A-Z)
                                                                           PAL 11910
          INTEGER ISYM (8, 20), ISYM'1 (8, 20), IBUF (8, 20), IVECT (20), IVECTP (20),
                                                                           PAL 11920
                 ISTATE (20), ISTATT (20), IPIN (20), TITLE (80), IPCTR
                                                                           PAL 119力0
                                                                           PAL 11940
          LOGICAL LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR,
                                                                           2AL 11950
                 LFIX, LSAME, XORFND, LERR, LPHASE (20), LPHAS1 (20), LBUF (20),
         2
                 LOUT (20), LOUTP (20), LCLOCK, LPTRST, LCTRST, LENABL (20), NREG,
                                                                           PAL 11960
                 LSAII, LSAI2, LSAOI
                                                                           PAL 11970
                                                                           PAL 11980
          INTEGER
                   BEL
                 LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR
          COMMON
                                                                           PAL 11990
          COMMON /PGE/ IPAGE(80,200)
                                                                           PAL 12000
                                                                           PAL 12010
          COMMON /LUNIT/ PMS, POF, PDF
          COMMON /FTEST/ IFUNCT, IDESC, IF
                                                                           PAL 12020
          DATA IDASH/!-!/,L/!L!/,H/!-
                                                 C1/,2/121/, NO/101/,
                                                                           PAL 12030
              N1/'1'/, ERR/'?'/, IB'
                                                  1:1/,14/141/,16/161/,
                                                                           PAL 12040
              18/181/
                                                                           PAL 12050
          DATA BEL/20700000/
                                                                           PAL 12060
INT ._
         PRINT AN ERROR MEST
                                                                           PAL 1207 U
                                                    TS SUPPLIED
COUN.
                                                                           PAL 12080
          IF (IFUNCT, NE. 0)
LAR EQN.
         WRITE (PMS, 2)
                                                                           PAL 12090
      ? FORMAT (/, FU
                                                       "RDER TO PERFORM".
                                                                           PAL 12100
```

С

С

C

90 IPCTR2=0

INITIALLY THERE ARE NO F

TOTAL NUMBER OF PRODUCT

IPCTR3 IS THE PRODUCT '

```
FILE: PAL20 FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
                                                                         PAL 12110
               ' SIMULATION')
                                                                          PAL 12120
     RETURN
                                                                         PAL 12130
     PRINT TITLE
                                                                         PAL 12140
    3 IF ((.NOT.LSA11).AND.(.NOT.LSA01)) WRITE (POF.4) TITLE
                                                                        PAL 12150
    4. FORMAT (/, 1 1,80A1,/)
      INITIALIZE LERR (FUNCTION TABLE ERROR FLAG) TO NO ERROR
                                                                         PAL 12160
                                                                        PAL 1217U
      LERR= FALSE.
      INITIALIZE NERR (NUMBER OF FUNCTION TABLE ERRORS) TO NO ERRORS
                                                                         PAL 12 180
C
                                                                         PAL 12190
      INITIALIZE ITRST (THREE-STATE ENABLE FUNCTION TABLE PIN NUMBER)
                                                                         PAL 12200
c
                                                                         PAL 12210
      ITRST=0
      SET THE STARTING POINT OF THE FUNCTION TABLE TO COLUMN 0
                                                                          PAL 12220
C
     AND IFUNCT + 1
                                                                          PAL 12230
С
      IC=0
                                                                         PAL 1224J
                                                                          PAL 12250
      IL=IFUNCT + 1
                                                                          PAL 12260
C
      INITIALIZE SA1/SAO PARAMETERS
      IPCTR3=0
                                                                          PAL 12270
                                                                          PAL 12260
      IEQN=0
      IPCTR=0
                                                                          PAL 12290
C
                                                                          PAL 12300
Ċ
      MAKE A DUMMY CALL TO INCR
                                                                          PAL 12310
      CALL INCR (IC, IL, LFIX)
                                                                         PAL 12320
      GET THE FUNCTION TABLE PIN LIST (UP TO 18)
С
                                                                         PAL 12330
C
      GO ONE MORE THAN MAX TO LOOK FOR DASHED LINE
                                                                         PAL 12340
                                                                         PAL 12350
      DO 10 I=1.19
      CALL GETSYM(LPHAS1, ISYM1, I, IC, IL, LFIX)
                                                                         PAL 12360
                                                                      PAL12370
        DO 5 J=1.8
                                                                         PAL 12360
         IBUF(J, 1) = ISYM1(J, 1)
     IF (IBUF (8, 1) . EQ. IDASH) GO TO 12
                                                                         PAL 12393
                                                                        PAL 12400
      CALL MATCH (IMATCH, IBUF, ISYM)
                                                                        PAL 12410
     IF (INATCH, NE.O) GO TO 7
                                                                        PAL 12420
      WRITE (PMS, 6) (IBUF (J, 1), J=1, 8)
                                                                        PAL12430
    6 FORMAT (/, * FUNCTION TABLE PIN LIST ERROR AT*, 8A1)
                                                                        PAL 12440
      RETURN
    7 LOUT(I) = . FALSE.
                                                                         PAL12450
                                                                         PAL 12460
      ISTATT(I) = X
                                                                         PAL 12470
      IVECTP(I)=X
ίs
     IF APPROPIATE PAL TYPE, REMEMBER LOCATION OF CLOCK AND THREE-STATEPAL 12480
c)
      ENABLE PIN IN FUNCTION TABLE PIN LIST
                                                           PAL 12490
      IF (ITYPE.NE.6) GO TO 10
                                                                         PAL 12500
      IF (IMATCH, EQ. 1) ICLOCK=I
                                                                         PAL 12510
      IF (IMATCH, EQ. 11) ITRST=I
                                                                         PAL 12520
   10 IPIN(I) = IMATCH
      ALL SIGNAL NAMES FOR THE FUNCTIONAL TEST HAVE BEEN READ IN
C
С
      ADJUST COUNT
                                                                          PAL 12560
   12 IMAX=I-1
      NVECT=0
                                                                          PAL12570
                                                                          PAL 12580
C
C*****START OF MAIN LOOP FOR SIMU
                                                                          PAL 12590
                                                                          PAL12600
С
```

PAL12610 1 PAL12620 AGE

PAL12630

PAL 12640

PAL12650

TO

WER FOR

T.

```
FILE: PAL20
              FORTRAN A
                            NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      O=WZZI
                                                                             PAL12660
      IPCTR3=0
                                                                             PAL 12670
                                                                             PAL 12680
      LSA 12= . FALSE .
                                                                             PAL12690
      LSA02=. FALSE.
C
                                                                             PAL12700
      NVECT=NVECT+1
                                                                             PAL 12710
      ICI=0
                                                                             PAL12720
      ILI=ILE
                                                                             PAL 12730
С
      GO PASSED COMMENT LINES
                                                                             PAL12740
   23 IF (IPAGE (1, IL) . NE. COMENT) GO TO 24
                                                                             PAL12750
                                                                             PAL12760
      IL=IL+1
      GO TO 23
                                                                             PAI.12770
   24 CONTINUE
                                                                             PAL12780
C
      GETS VECTORS FROM FUNCTION TABLE
                                                                             PAL 12790
      DO 20 I=1, IMAX
                                                                             PAL 12803
        IF (IPAGE (IC, IL) . EQ. IBLANK) GO TO 21
                                                                             PAL 12810
        GO TO 22
                                                                             PAL1282J
   21
        IC=IC+1
                                                                             PAL12830
        IF (IPAGE (IC, IL) . EQ. IBLANK) GO TO 21
                                                                             PAL12840
   22 IVECT(I) = IPAGE(IC, IL)
                                                                            PAL12850
        IC=IC+1
                                                                             PAL12860
   20 CONTINUE
                                                                             PAL12870
      ADVANCE LINE COUNT TO SKIP FUNCTION TABLE COMMENTS
                                                                             PAL 12880
                                                                             PAL12890
      IL=IL+1
      IC = 1
                                                                            PAL 12900
      IF (IVECT (1), EQ. IDASH) GO TO 95
                                                                            PAL 12910
C
      CHECK FOR VALID FUNCTION TABLE VALUES (L.H.X.Z.C)
                                                                            PAL 12920
      DO 11 I=1, IMAX
                                                                            PAL12930
         IF ( IVECT (I) .EQ.L.OR.IVECT (I) .EQ.H.OR.IVECT (I) .EQ.X.OR.
                                                                            PAL 12940
              IVECT(I).EQ.Z.OR.IVECT(I).EQ.C) GO TO 11
                                                                            PAL12950
         WRITE (PMS. 8) IVECT (I) . NVECT
                                                                             PAL12960
         FORMAT (/, * , A ), * 15 NOT AN ALLOWED FUNCTION TABLE ENTRY ,
    Я
                                                                             PAL12970
                           * IN VECTOR ',13)
                                                                             PAL 12980
                                                                             PAL12990
         RETURN
                                                                             PAL13000
   11 CONTINUE
С
      INITIALIZE CLOCK AND THREE-STATE ENABLE FLAGS
                                                                             PAL 13010
      LCLOCK=.FALSE.
                                                                             PAL13020
      LCTRST=.TRUE.
                                                                             PAL13030
      LPTRST= .TRUE.
                                                                             PAL13040
                                                                             PAL 1305 G
      DO 13 I=1, IMAX
   13
                                                                             PAL 13060
         LENABL(I) = . TRUE.
С
      INITIALIZE NREG (NOT REGISIERED OUTPUT) TO FALSE
                                                                             PAL13070
      NREG=. FALSE.
                                                                             PAL 13080
c
      INITIALIZE ISTATE ARRAY TO ALL X'S
                                                                             PAL13090
      DO 15 I=1,20
                                                                             PAL 13 100
   15 ISTATE (I) = X
                                                                             PAL13110
c
      CHECK IF THIS PAL TYPE HAS RECISTERS
                                                                             PAL13120
      IF (ITYPE. NE. 6) GO TO 25
                                                                             PAL 13130
      CHECK CLOCK AND THREE-STATE ENABLE PINS AND CHANGE FLAG IF NEEDED PALISIAGO
c
      IF (IVECT (ICLOCK) . EQ.C) LCLOCK = . TRUE .
                                                                             PAL 13 150
      IF (ITRST.EQ. 0) GO TO 25
                                                                             PAL 13 160
                                            LPHASI(ITRST)).OR.
                     LPHASE(II)).AND.(
                                                                             PAL13170
      LSAME= ( (
               (.NOT.LPHASE(11)).AND.(.NOT.LPHAS1(ITRST)))
                                                                            PAL 13 180
      IF ( IVECT (ITHST) . LQ. L. AND. (. NOT. LSAME) . OR.
                                                                            PAL 13130
          IVECT (ITRST) . EQ.H.AND. (
                                      LSAME) ) LPTRST=, PALSE,
                                                                            PAL 13200
```

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FILE: PAL20
                FORTRAN A
                              NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      IF (LPTRST) GO TO 25
                                                                                PAL13210
      DISABLE REGISTERED OUTPUTS IF APPROPRIATE
C
                                                                                PAL13220
                                                                                PAL13230
      DO 46 I=1.IMAX
                                                                               PAL13240
          J=IPIN(I)
          IF (J. EQ. 14. OR. J. EQ. 15. OR. J. EQ. 16. OR. J. EQ. 17) LENABL (I) = FALSE. PAL 13250
          IF ( INOO. EQ. 16. AND. (J. EQ. 13. OR. J. EQ. 18) )
                                                            LENABL(I) = . FALSE. PAL13260
          IF ( INOO. EQ. 18. AND. (J. EQ. 12. OR. J. EQ. 13
                                                                                PAL13270
                            .OR.J.EQ.18.OR.J.EQ.19) )
                                                          LENABL(I) = . FALSE. PAL13280
   46 CONTINUE
                                                                                PAL 13290
C
                                                                                PAL 13300
C*****SCAN THROUGH THE LOGIC EQUATIONS****
                                                                                PAL 13310
C
                                                                                PAL 13320
      MAKE A DUMMY CALL TO INCR
C
                                                                              PAL 13330
   25 CALL INCR (IC1, IL1, LFIX)
                                                                                PAL13340
   26 CALL GETSYN (LBUF, 18UF, 1, 1C1, TL1, LFIX)
                                                                                PAL13350
      IF (LLEFT) GO TO 29
   27 IF (.NOT.LEQUAL) GO TO 26
c
                                                                                CBEELIAS
      IF (LEQUAL) IEON=IEON+1
                                                                                PAL 13390
c
                                                                                PAL 13400
C
      EVALUATE CONDITIONAL THREE-STATE PRODUCT LINE
                                                                                PAL 13410
   29 IF (LEQUAL) GO TO 35
                                                                                PAL 13420
      NREG=.TRUE.
                                                                                PAL13430
   33 CALL GETSYM(LBUF, IBUF, 1, IC1, IL1, LFIX)
                                                                                PAL 13440
      CALL MATCH (IINP. IBUF. ISYM1)
                                                                                PAL13450
      CHECK FOR GND, VCC, /GND, OR /VCC IN CONDITIONAL THREE-STATE
                                                                              : PAL 13460
С
                                                                               PAL 13470
C
       PRODUCT LINE
      IF (IINP.NE.O) GO TO 32
                                                                                PAL 13480
                                                                                PAL 13490
      CALL MATCH (IMATCH. IBUF, ISYM)
                                                                                PAL13500
      ILL=IL!
                                                                                PAL 13510
      IF ( IINP.EQ.O. AND. IMATCH. NE. 10. AND. IMATCH. NE. 20 ) GO TO 100
                                                                                PAL13520
      IF ( IMATCH.EQ. 10. AND. (LBUF (1)).OR.
           IMATCH.EQ. 20. AND. (.NOT. LBUF (1)) ) LCTRST=.FALSE.
                                                                                PAL13530
                                                                                PAL13540
      GO TO 34
   32 ITEST=IVECT (IINP)
                                                                                PAL 13550
     IF ( ITEST.EQ.L.AND. ( LPHASI(IINP)).AND. ( LBUF(1))
I.OR. ITEST.EQ.H.AND. ( LPHASI(IINP)).AND. (.NOT.LBUF(1))
                                                                                PAL13560
                                                                               -PAL 13570
     2.OR. ITEST.EQ.H.AND. (.NOT.LPHAS1(IINP)).AND. ( LBUF(1))
                                                                               PAL13580
     3.OR. ITEST.EQ.L.AND. (.NOT.LPHAS1(IINP)).AND. (.NOT.LBUF(1)).
                                                                                PAL 13590
  LCTRST=.FALSE.
                                                                                PAL13600
                                                                                PAL13610
      IF (ITEST. EQ. X. OR. ITEST. EQ. Z) LCTPST = . FALSE.
   34 IF (LAND) GO TO 33
                                                                                PAL 13620
      GO TO 27
                                                                                PAL13630
C
                                                                                PAL13640
С
      EVALUATE THE LOGIC EQUATION
                                                                                PAL13650
C
                                                                                PAL13660
C
      FIND THE PIN NUMBER OF THE OUTPUT VECTORS
                                                                                PAL13670
C
                                                                                PAL13680
   35 IPCTR3=0
                                                                                PAL 13690
C
                                                                                PAL 13700
      CALL MATCH (IOUTP, IBUF, ISYM1)
                                                                               PAL13710
                                                                              PAL13720
c
      FLAG UNREGISTERED OUTPUTS
      CALL MATCH (IOUT, IBUF, ISYM)
                                                                                PAL13730
      IF (ITYPE, LE, 5) NREG=.TRUE.
                                                                               PAL13740
      IF( (INOO.EQ.14.OR.INOO.EQ.16).AND.(IOUT.EQ.12.OR.IOUT.EQ.19) ) PAL13750
```

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FILE: PALZO FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
            NREG = . TRUE.
                                                                                 PAL13760
      IF ( (INOO. EQ.14) . AND. (IOUT. EQ. 13. OR. IOUT. EQ. 18) ) NREG=.TRUE.
                                                                                 PAL 13770
                                                                                 PAL13780
      ILL=IL1
       IF (IOUTP, EQ. 0) GO TO 100
                                                                                 PAL13790
      IF (NREG) LENABL (IOUTP) = LCTRSI
                                                                                 PAL 13800
                                                                                 PAL13810
      LOUT (IOUTP) = . TRUE.
      IF ( .NOT.LCTRST ) LOUT (IOUTP) = .FALSE.
                                                                                 PAI. 13820
                                                                                 PAL13830
      LCTRST=.TRUE.
                                                                                 PAL 13840
       LOUTP (10UTP) = LBUF (1)
      DETERMINE PRODUCT TERM AND EVENTUALLY SUM FOR OUTPUT KEEPING
C.
                                                                                 PAL 13850
c
       TRACK TO SEE IF AN XOR (EXCLUSIVE OR) HAS BEEN FOUND
                                                                                 Pal 13860
      XORSUM=H
                                                                                 PAL13870
      XORFND=.FALSE.
                                                                                 PAL13880
      ISUM=L
                                                                                 PAL13890
С
                                                                                 PAL13900
                                                                                 PAL13910
   28 IPCTR2=IPCTR2+1
      IPCTR 3=IPCTR3+1
                                                                                 PAL 13920
С
                                                                                  PAL13930
      IPCTR=IPCTR+1
                                                                                 PAL13940
      IPROD=H
                                                                                  FAL13950
   36 ILL=1L1
                                                                                 PAL 13960
      CALL GETSYM (LBUF, IBUF, 1, IC1, IL1, LFIX)
                                                                                 PAL13970
       IF ( .NOT.LFIX ) GO TO 39
                                                                                 PAL 13980
С
       EVALUATE THE FIXED SYMBOLS FOUND IN THE PALIEX4 AND PALIEA4
                                                                                 PAL13990
           LFIX=. FALSE.
                                                                                 PAL14000
                                                                                 PAL14010
           CALL FIXTST (LPHAS1, LBUF, IC1, IL1, ISYM, ISYM1, IBUF,
                         IVECT, IVECTP, ITEST, LCLOCK, NREG, LFIX)
                                                                                 PAI. 14020
           IF (IPROD. EQ. H) IPROD=ITEST :
                                                                                 PAL14030
          GO TO 38
                                                                                 PAL14040
                                                                                 PAL14050
   39 CALL MATCH (IINP, IBUF, ISYMI)
                                                                                 PAL 14060
      IF (IINP.NE.O) GO TO 47
                                                                                 PAL 14070
      CALL MATCH (IMATCH, IBUF, 15YM)
      IF (IMATCH, NE. 10, AND, INATCH, NE. 20) GO TO 100
                                                                                 PAL 14080
                                                                                 PAL 14090
С
      TWEEK FOR GND AND VCC IN PRODUCT LINE
                                                                                 PAL 14 100
      IF (IMATCH. EQ. 13) ITEST=L
      IF (IMATCH, EQ. 20) ITEST=H
                                                                                 PAL 14 110
      IINP=19
                                                                                 PAL 14 120
                                                                                 PAL14130
      LPHASI(19) = . TRUE.
      GO TO 37
                                                                                 PAL 14 14 0
   47 ITEST=IVECT(IINP)
                                                                                 PAL 14 150
С
      GET REGISTERED FEED BACK VALUES
                                                                                 PAL 14 160
      IF (NREG) GO TO 37
                                                                                 PAL 14 170
      CALL MATCH (IIFB, IBUF, ISYM)
                                                                                 PAL 14 180
      IF ( (1NOO.EQ.14.OR.INOO.EQ.16.OR.INOO.EQ.18).AND.
                                                                                 PAL 14 190
                                                                                 PAL 14 200
          (IIFB.EQ.14.OR.IIFB.EQ.15.OR.IIFB.EQ.16.OR.IIFB.EQ.17) )
            ITEST=IVECTP (IINP)
                                                                                 PAL14210
      IF( (INOO.EQ.16.OR.INOO.EQ.18).AND.(IIFB.EQ.13.OR.IIFB.EQ.18))
                                                                                 PAL 14220
            ITEST=IVECTP (IINP)
                                                                                  PAL 14230
      IF ( INOO. EQ. 18. AND. (11FB. EQ. 12. OR. 11FB. EQ. 19) )
                                                                                 PAL 14 24 0
            ITEST=IVECTP (IINP)
                                                                                 PAL 14 250
   37 IF ( ITEST.EQ.X.OR.ITEST.EQ.Z ) ITEST=L
                                                                                 PAL 14260
     IF ( ITEST.EQ.L.AND. ( LPHASI(IINP)).AND. ( LPHASI(IINP)).AND. ( LPHASI(IINP)).AND. (...
                                                             LBUF(1))
                                                                                 PAL 14270
                                   LPHASI(IINP)), AND. (, NOT. LBUF(1))
                                                                                 PAL 14280
     2.OR. ITEST.EQ.H.AND.(.NOT.LPHAS!(IINP)).AND.( LBUF(1))
                                                                                 PAL 14290
     2.OR. ITEST.EQ.H.AND.(.NOT.LPHASI(IINP)).AND.( LBUF(I))
3.OR. ITEST.EQ.L.AND.(.NOT.LPHASI(IINP)).AND.(.NOT.LBUF(I))
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FILE: PAL20
                FORTRAN A
                              NSC TIME SHARING SERVICES VM/SP RELEASE 2,0
     4 )
            IPROD=L
                                                                              PAL 14 310
C
                                                                              PAL14-320
C
      CHECK FOR A PARTICULAR PRODUCT TERM AND GO FOR SAI TEST
                                                                              PAL14330
      IF ((IPCTR2, EQ, IPCTR1), AND, (LSA11)) GO TO 110
                                                                              PAL 14340
С
                                                                              PAL 14350
   38 IF (LRIGHT) CALL INCR(IC1.IL1.LFIX)
                                                                              PAL14360
      IF (LAND) GO TO 30
                                                                              PAL14370
c
                                                                              PAL 14380
C
      CHECK FOR A PARTICULAR PRODUCT TERM AND GO FOR SAU TEST
                                                                              PAL 14390
      IF ((IPCTR2, EQ, IPCTR1), AND, (LSA01)) GO TO 120
                                                                              PAL 14400
C
                                                                              PAL14410
  121 IF (ISUM. EQ.L. AND. IPROD. EQ.X) ISUM=X
                                                                              PAL 14420
      IF ( (ISUM. NE. H) . AND . IPROD . EQ . H ) ISUM = H
                                                                              PAL 14430
c
      CHECK FOR XOR (EXCLUSIVE OR) AND SAVE INTERHEDIATE VALUE
                                                                              PAL14440
      IF (.NOT.LXOR) GO TO 31
                                                                              PAL14450
      XORSUM=ISUM
                                                                              PAL 14460
      XORFND= TRUE.
                                                                              PAL14470
      ISUM=L
                                                                              PAL14483
      GO TO 28
                                                                              PAL 14490
   31 IF (LOR) GO TO 28
                                                                              PAL 14500
      IPCTR3=0
                                                                              PAL 14510
С
      IF END OF EQUATION HAS BEEN FOUND, DETERMINE FINAL SUM AND SAVE ITPAL 14520
      IF (.NOT. XORFND)
                           ISTATT (IOUTP) = ISUM
                                                                              PAL14530
      IF ( (XORFND) . AND. ((ISUM. EQ. L. AND. XORSUM. EQ. L) .OR.
                                                                              PAL 14540
                          (ISUM.EQ.H.AND.XORSUM.EQ.H)) ) ISTATT (IOUTP) =L
                                                                              PAL 14550
      IF ( (XORFND) . AND . ((ISUN . EQ . H . AND . XORSUM . EQ . L) . OR .
                                                                              PAL 14560
                          (ISUM.EQ.L.AND.XORSUM.EQ.H)) ) ISTATT (IOUTP) =H
                                                                              PAL14570
      PAL14580
      REGISTER DOES NOT CHANGE STATE IF NO CLOCK PULSE IS RECEIVED
                                                                              PAL 14590
      IF ( (LCLOCK), OR, (NREG) ) GO TO 36
                                                                              PAL 14600
      LSAME = ( (
                                                 LPHASI (IOUTP)).OR.
                        LOUTP (IOUTP)) . AND. (
                                                                              PAL 14610
                 (.NOT.LOUTP(IOUTP)).AND.(.NOT.LPHASI(IOUTP)))
                                                                              PAL14620
      IF ( IVECTP (IOUTP) . EQ. L. AND. ( LSAME) ) ISTATT (IOUTP) = L
                                                                              PAL 14630
      IF ( IVECTP (IOUIP) . EQ. H. AND. (
                                          LSAME) ) ISTATT (IOUTP) = H
                                                                              PAL 14640
      IF ( IVECTP (IOUTP) . EQ., L. AND. (. NOT. LSAME) ) ISTATT (IOUTP) = H
                                                                              PAL 14650
      IF ( IVECTP (1 OUTP) . EQ. H. AND. (, NOT. LSAME) ) ISTATT (IOUTP) = L
                                                                              PAL14660
   36 NREG=.FALSE.
                                                                              PAL14670
c
      CHECK IF ALL EQUATIONS HAVE BEEN PROCESSED BY COMPARING CURRENT
                                                                              PAL14680
C
       LINE NUMBER WITH FUNCTION TABLE LINE NUMBER
                                                                              PAL14690

    IF (IDESC, NE.O. AND.IL1.LT.IFUNCT.AND.IL1.LT.IDESC.OR.

                                                                              PAL 14700
         IDESC. EQ. O. AND. ILI. LT. IFUNCT) GO TO 27
                                                                              PAL 14710
c
      DETERMINE OUTPUT LOGIC VALUES
                                                                              PAL 14720
c
       COMPARE OUTPUTS TO SEE IF VECTOR AGREES WITH RESULTS
                                                                              PAL 14730
      DO 50 I=1, IMAX
                                                                              PAL14740
                                                                            ~ PAL 14750
      IF ( .NOT.LOUT(I) ) GO TO 50
      IF ( ISTATT (I) . EQ. X. AND . I V ECT (I) . EQ. X ) GO TO 50
                                                                              PAL14760
                                                                              PAL14770
      LSAME = ( (
                        LOUTP(I)).AND.( LPHASI(I)).OR.
                  (.NOT.LOUTP(I)), AND. (.NOT.LPHAS1(I))
                                                                              PAL 14780
      IMESS=40
                                                                              PAL 14790
      IF (ISTATT (I) . EQ. L. AND. IVECT (I) . EQ. L. AND. (.NOT. LSAME)) IMESS=41
                                                                              PAL 14800
      IF (ISTATT (1) .EQ. H. AND. IVECT (1) .EQ. H. AND. (.NOT. LSAME)) IMESS=42
                                                                              PAL 14810
      IF (ISTATT (I) . EQ. L. AND. IVECT (I) . EQ. H. AND. ( LSAME)) IMESS=42
                                                                              PAL 14820
      IF (ISTATT (I) . EQ. d. AND. IVECT (I) . EQ. L. AND. (
                                                        LSAME)) IMESS=41
                                                                              PAL 14830
                 LENABL(I)).AND.IVECT(I).EQ.Z)
                                                                 TMESS=43
                                                                              PAL 14840
      IF ( (.NOT.LENABL(I)).AND.(LOUT(I)).AND.IVECT(I).NE.Z) IMESS=44
                                                                              PAL14850
```

```
PAL 14860
      IF (IMESS.NE. 40) LERR=. IRUE.
c
                                                                                  PAL 1487 J
C
      IF NO FAULT GO FOR NEXT VECTOR ELSE GET OUT OF SIMULATION AND
                                                                                  PAL 14880
      START SIMULATION FOR THE NEXT PRODUCT TERM.
С
                                                                                  2AL 14890
      IF ((. NOT. LERR) . AND. ((LSA11) . OR. (LSA01))) GO TO 50
                                                                                  PAL 14900
      IF ((LERR), AND. ((LSA11), OR. (LSAU1))) GO TO 115
                                                                                  PAL 14910
c
                                                                                  PAL 14920
      IF (IMESS. EQ. 41) WRITE (PMS, 41) NVECT, (ISYM1(J, 1), J=1,8)
                                                                                  PAL 14930
   41 FORMAT(/, * FUNCTION TABLE ERROR IN VECTOR*, 13, * PIN = *, 3A1,
                                                                                  PAL14940
                    EXPECT = H ACTUAL = L')
                                                                                  PAL 14950
      IF (IMESS, EQ. 42) WRITE (PMS, 42) NVECT, (ISYM1(J, I), J=1,8).
                                                                                  PAL 14960
   42 FORMAT (/, FUNCTION TABLE ERROR IN VECTOR, 13, PIN = , 3A1.
                                                                                  PAL 14970
                    EXPECT = L ACTUAL = H<sup>1</sup>)
                                                                                  PAL 14980
      IF (IMESS, EQ. 43) WRITE (PMS, 43) AVECT, (ISYM1(J, I), J=1,8)
                                                                                  PAL 14990
   43 FORMAT (/, FUNCTION TABLE ERROR IN VECTOR , I3, PIN = 1, 841,
                                                                                  PAL 15000
                    EXPECT = OUTPUT ENABLE ACTUAL = Z1)
                                                                                  PAL 15010
      IF (IMESS. EQ. 44) WHITE (PMS, 44) NVECT, (ISYM1 (J. I) , J=1,8), IVECT (I)
                                                                                  PAL 15020
   44 FORMAT (/, FUNCTION TABLE ERROR IN VECTOR 1, 13, PIN = 1,641,
                                                                                  PAL15030
                    EXPECT = Z ACTUAL = ', Al)
                                                                                  PAL 15040
      IF ( (IMESS, NE. 40) .AND. (PMS. EQ. 6) ) WRITE (PMS, 45) BEL
                                                                                  PAL 15050
   PAL 15060
       IF (IMESS.NE. 40) IVECT (I) = ERR
                                                                                  PAL 15070
       IF (IMESS. NE. 40) NERR=NERR+1
                                                                                  PAL 15080
                                                                                  PAL 15090
   50 CONTINUE
C
       CHANGE THE ORDER OF VECTORS FROM THE ORDER OF APPEARANCE IN THE
                                                                                  PAL 15 100
        FUNCTION TABLE TO THAT OF THE PIN LIST AND IWEEK FOR OUTPUT
                                                                                  PAL 15110
c
       DO 65 I=1,20
                                                                                  PAL 15 120
          DO 55 J=1, IMAX
                                                                                  PAL 15 130
          IF (IPIN (J), NE, 1) GO TO 55
                                                                                  PAL 15 140
                                                                                  PAL 15 150
          IF ( IVECT (J) .EQ.L.OR.IVECT (J) .EQ.H ) GO TO 51
                                                                                  PAL 15 16 0
          ISTATE(I) = IVECT(J)
                                                                                  PAL 15 170
          GO TO 65
          LSAME= ( (
   5 1
                          LPHASE (I)) .AND. (
                                                LPHAS 1 (J)).OR.
                                                                                  PAL 15 180
                   (.NOT.LPHASE(1)).AND.(.NOT.LPHASI(J)))
                                                                                  PAL 15 190
          IF ( INOO. EQ. N1. AND. (I. EQ. 15. OR. I. EQ. 16) )
                                                           LOUT (J) = .TRUE.
                                                                                  PAL 15 20 0
                                           LSAME) . AND'.
                                                                                  PAL 15210
          IF ( (.NOT.LOUT (J)).AND. (
      i
                 IVECT (J) .EQ.L )
                                                           ISTATE (I) = NO
                                                                                  PAL 15220
          IF ( (.NOT.LOUT (J)) .AND. (
                                           LSAME) . AND.
                                                                                  PAL 15230
                                                                                  PAL 15 24 0
      1
                 IVECT (J) .EQ. H )
                                                           ISTATE (I) = N 1
                                                                                  PAL 15250
          IF ( (.NOT.LOUT (J)) .AND. (.NOT.LSANE) .AND.
      1
                 IVECT (J) . EQ.L )
                                                           ISTATE (I) = N 1
                                                                                  PAL 15260
          IF ( (.NOT.LOUT (J)) .AND. (.NOT.LSAME) .AND.
                                                                                  PAL 15270
                                                           ISTATE (I) =NO
                                                                                  PAL 15280
                 IVECT (J) . EQ. H )
         IF( (
                     LOUT (J)) . AND. (
                                           LSAME) . AND.
                                                                                  PAL 15290
      1
                 IVECT (J) . EQ. L. AND. (
                                            LENABL(J)) ISTATE(I)=L
                                                                                  PAL 15300
                                                                                  PAL 15310
          IF ( (
                     LOUT (J)) .AND. (
                                           LSAME) . AND.
                                                                                  PAL 15320
      1
                 IVECT (J) .EQ.H.AND. (
                                            LENABL(J)) | ISTATE(I) = H
                                                                                  PAL 15330
          IF ( (
                     LOUF (J)) .AND. (.NOT.LSAME) .AND.
                                                                                  PAL 15340
      1
                 IVECT (J) . EQ. L. AND. (
                                            LENABL(J)) | ISTATE(I) = H
                                                                                  PAL 15350
         IF ( (
                     LOUT (J) ) .AND. (.NOT.LSAME) .AND.
      1
                                            LENABL(J)) | ISTATE(I)=L
                                                                                  PAL 15300
                 IVECT (J) .EQ.H.AND. (
          IF ( IVECT (J) . EQ. ERR )
                                                           ISTATE (I) = ERR
                                                                                  PAL 15370
          GO TO 65
                                                                                  PAL 15 380
```

NSC TIME SHARING SERVICES VM/SP RELEASE 2.0

FILE: PALZO

55 CONTINUE

c

FORTRAN A

PAL 15390

SAVE PRESENT VECTORS FOR FEED BACK USED WITH NEXT SET OF VECTORS PAL15400

```
FILE: PAL20 FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
c
       IF CLOCK PULSE AND NOT 2 (HI-Z IS ASYNCHRONOUS)
                                                                                  PAL 15410
   65 IF ( (LCLOCK) .AND. IVECT (J) .NE. 2 ) IVECTP (J) = IVECT (J)
                                                                                  PAL 15420
       ASSIGN X TO GROUND PIN AND 1 TO VCC PIN
                                                                                 PAL 15430
       ISTATE (10) = X
                                                                                  PAL 15440
      ISTATE (20) = N 1
                                                                                 PAL 15450
C
      PRINT TEST VECTORS
                                                                                  PAL 15460
      IF ((.NOT.LSA11).AND.(.NOT.LSA01)) WRITE (POF.60)
     1 NVECT, (ISTATE(I), I=1, 20)
   60 FORMAT( 1,13, 1,20A1)
      GO TO 90
С
      TERMINATE SIMULATION
   95 IF ((.NOT.LERR).AND. (LSAII)) WRITE (POF, 150) IPCTR4, IEQNI
  150 FORMAT (' ', ' PRODUCT: ', 13, ' OF ', 'EQUATION, ', 13, '
                                                                                 PAL 15540
     1 UNTESTED (SA1) FAULT')
                                                                                 PAL15550
      IF ((.NOT.LERR).AND. (LSAD1)) WHITE (POF, 155) IPCTR4, IEQN1
                                                                                 PAL 15560
  155 FORMAT(' ', ' PRODUCT: ', 13, ' OF ', 'EQUATION,', 13, '
                                                                                 PAL 15570
     1 UNTESTED (SAO) FAULT')
                                                                                 PAL 15580
c
      IF ((,NOT.LERR) .AND. ((,NOT.LSA11) .AND. (,NOT.LSA01))) WRITE (POF,67) PAL 15600
   67 FORMAT (/, PASS SIMULATION')
                                                                                  PAL15610
      IPCTR=IPCTR/(NVECT-1)
              LERR) .AND. ((.NOT.LSAII) .AND. (.NOT.LSAOI)))
                                                                                  PAL 15630
     IWRITE (POF, 68) NERR
                                                                                  PAL 15640
   68 FORMAT(/, NUMBER OF FUNCTION TABLE ERRORS = 1, 13)
                                                                                  PAL 15650
      RETURN
                                                                                  PAL 15660
      PRINT AN ERROR MESSAGE FOR AN UNDEFINED PIN NAME
                                                                                  PAL 1567G
  100 ILERR=ILL+4
                                                                                  PAL15680
  WRITE (PM5, 101) (IBUF (1,1), I=1,8), ILERR, (IPAGE (I,ILL), I=1,80)

101 FORMAT (/, 'ERROR SYMBOL = ',841,' IN LINE NUMBER ',13,

1 /,'',8041,/,' THIS PIN NAME IS NOT DEFINED IN THE',

2 'FUNCTION TABLE PIN LIST')
                                                                                  PAL 15690
                                                                                  PAL 15700
                                                                                  PAL15720
      RETURN
                                                                                  PAL 15730
C
                                                                              . PAL 15740
       THE PRODUCT TERM IS PULLED HIGH AND THE PRODUCT NUMBER
C
                                                                                  PAL15750
С
       AND EQN NUMBER IS REMEMBERED
                                                                                  PAL 15760
  110 IPROD=H
                                                                                  PAL 15770
      LSA12= TRUE.
                                                                                  PAL 15780
      IEQNI=IEQN
                                                                                  PAL 15790
      IPCTR4=IPCTR3
                                                                                  PAL 15800
      GO TO 38
                                                                                  PAL 15810
С
                                                                                  PAL 15820
c
                                                                                  PAL15830
C
                                                                                  PAL15840
      THE PRODUCT TERM IS TESTED FOR SAU FAULT AND ALSO REMEMBERED
                                                                                  PAL 15850
  120 IPROD=L
                                                                                  PAL 15860
      LSA02= TRUE.
                                                                                  PAL 15870
      IEQNI=IEQN
                                                                                  PAL 15880
      IPCTR4=IPCTR3
                                                                                  PAL15890
      GO TO 121
                                                                                  PAL15900
c
                                                                                  PAL 15910
С
                                                                                  PAL 15920
С
                                                                                  PAL 15930
      IF NO FAULT THEN NEXT PRODUCT TERM
                                                                                  PAL 15940
  115 ISAF=ISAF+1
                                                                                  PAL 15950
```

```
LERR= . FALSE .
                                                                              PAL 15960
      RETURN
                                                                              PAL 15970
C
                                                                              PAL 15980
      END
                                                                              PAL 15990
                                                                              PAL 16000
C
                                                                              PAL 16020
      SUBROUTINE FIXIST (LPHAS1, LBUF, IC1, IL1, ISYM, ISYM1, IBUF,
                                                                              PAL 1603J
                          IVECT, IVECTP, ITEST, LCLOCK, NREG, LFIX)
                                                                              PAL 16040
      THIS SUBROUTING EVALUATES THE FIXED SYMBOLS FOUND IN THE
                                                                              PAL 16050
С
       PALIGNA AND PALIGNA FOR THE FUNCTION TABLE
                                                                              FAL 16060
      IMPLICIT INTEGER (A-Z)
                                                                              PAL 16070
      INTEGER ISYM (8,20), ISYM1 (8,20), IBUF (8,20), IVECT (20), IVECTP (20)
                                                                              PAL 16080
      LOGICAL LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR,
                                                                              PAL 16090
     1
               LFIX, LPHAS1(20), LBUF(20), LCLOCK, NREG, TOR, TXOR, TXNOR, TAND, PAL16100
               LPHASA, LPhass
                                                                              PAL 16110
      COMMON LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXNOR
                                                                              PAL 16 120
      COMMON /PGE/ IPAGE (80, 200)
                                                                              PAL 16130
      DATA L/*L*/, H/'H*/, X/*X*/, Z/*2*/
                                                                              PAL 15 14 U
С
      GET OUTPUT PIN AN (WHERE N=0, 1, 2, 3)
                                                                             PAL 16 150
      CALL GETSYM(LBUF, IBUF, 1, IC1, IL1, LFIX)
                                                                              PAL 16 160
      CALL MATCH (IINP, IBUF, ISTMI)
                                                                              PAL 16170
      ITESTA=1VECT (IINP)
                                                                              PAL 16 180
      LPHASA = ( (
                                            LPHASI(IINP)).OR.
                        L3UF(1)).AND.(
                                                                              PAL 16 130
                  ( (QNII) 12 A H Q . ( . NOT . L P H A S 1 ( I I N P ) )
                                                                             PAL 15 20 0
C
      GET REGISTERED FEEL BACK VALUES
                                                                             PAL 16210
      IF (NREG) GO TO 5
                                                                              2AL 16220
      CALL MARCH (IIF3, IBUF, ISYM)
                                                                              PAL 10230
      IF( IIFB, 20, 14, 0A, IIFB, 20, 15, 0R, IIFB, E2, 16, 0A, IIFB, EQ, 17)
                                                                             PAL 16243
          ITESTA = IVECTP (IIAP)
                                                                             PAL 16 250
    5 IF ( (.NOI, LPHASA), AND, ITESIA, EQ. L ) GO TO 10.
                                                                             PAL 16260
      IF ( (.NOT.LPHASA) .AND.ITESTA.EQ.H .) GO TO 15
                                                                              PAL 16 270
      GO TO 20
                                                                              PAL 16280
   10 ITESTA=H
                                                                              PAL 16 29 0
      GO TO 20
                                                                              PAL 16300
   15 ITESTA=L
                                                                              PAI. 16310
   20 IF ( NOT, LRIGHT ) GO TO 25
                                                                             PAL 16320
            ITEST = ITESTA
                                                                              PAL 16330
            RETURK
                                                                              PAL 16340
C
      SAVE THE FIXED SYMBOL OPERATORS
                                                                             PAL 16350
   25 TOR
            = (LOR.AND.(.NOT.LXOR))
                                                                             PAL 16360
      TXOR = (LXOR)
                                                                             PAL 16370
      TXNOR = (LXNOR)
                                                                              PAL 16380
      TAND = (LAND.AND.(.NOT.LXNOR))
                                                                              PAL 16390
c
      GET INPUT BN (HERE N=0,1,2,3)
                                                                              PAL 15400
      CALL GETSYM(LBUF, IBUF, 1, IC1, IL1, LFIX)
                                                                              PAL 16410
      CALL MATCH (IINP, IBUF, 18481)
                                                                             PAL 16420
      ITESTB=IVECT (IINP)
                                                                             PAL 16430
      LPHASB = ( (
                                            LPHASI(IINP)).OR.
                         LBUF (1)) . AND. (
                                                                             PAL15440
                  (.NOT.LBUF(1)).AND.(.NOT.LPHAS1(IINP)))
                                                                             PAL 16450
      IF ( (.NOT.LPHASB) .AND.ITESTB.EQ.L ) GO TO 30
                                                                             PAL 16460
      IF ( (.NOT.LPHASB) .AND.ITESTB.E2.H ) GO TO 35
                                                                             PAL16470
      GO TO 40
                                                                              PAL 16480
   30 ITESTB=H
                                                                             PAL 16490
```

FORTRAM A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0

FILE: PAL20

GO TO 40

FILE: PAL20

RETURN END FORTRAN A

```
PAL 16510
 35 ITESTB=L
                                                                               PAL 16520
     EVALUATE THE FIXED SYMBOL EXPRESSION
                                                                               PAL 16530
40 ITEST=L
                                                                               PAL 16543
     IF(
           (TOR), AND, (ITESTA, EQ. H. OR, ITESTB, EQ. H) )
                                                                ITEST=H
           (TXOR) . AND. ((ITESTA, EQ. H. AND. ITESTB, NE. H) .OR.
                                                                               PAL 16550
     IF (
                        (ITESTA.NE.H.AND.ITESTB.EQ.H) ))
                                                                ITEST=H
                                                                               PAL 16560
     IF ( (TXNOR) . AND. ((ITESTA. EQ. ITESTB) . OR.
                                                                               PAL 16570
                        (ITESTA.EQ.X.OR.ITESTB.EQ.X) ))
                                                                ITEST=H
                                                                               PAL 16580
     IF ( (TAND) .AND. (ITESTA.NE.L.AND. ITESTB.NE.L) )
                                                                ITEST=H
                                                                               PAL 16590
     IF ( (ITESTA.EQ.X.OR.LTESTA.EQ.Z).AND.(ITESTB.EQ.X) ) ITEST=X
                                                                               PAL 16600
                                                                               PAL 16610
```

NSC TIME SHARING SERVICES VM/SP RELEASE 2.0

## Listing 2. PALASM Source Code for 24 Series

FILE: PAL24 FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0

P A '	t	Δ.	ς ,	4	,	(a	_	TRANSLATES ST	YMBOLIC EQUATIONS INTO PAL OBJECT	PALOOO PALOOO
	٠.			•	-	•			TED FOR DIRECT INPUT TO STANDARD	PALOUG
								PROM PROGRAM		PALOOO
								raon raoonan		PALOOO
								INSUL:	PAL JESIGN SPECIFICATION ASSIGNED	PALOOO
								1.11.01.	TO RPD(1). OPERATION CODES ARE	PALOOD
									ASSIGNED TO RUP (5).	PALOOU
									ASSISTED TO MOP (5).	PALOOI
								OUTPUT:	ECHO, SIMULATION, AND FUSE PATTERN	
										PALOOI
									BINARY PROGRAMMING FORMATS ARE	PALOOI
									· ·	PALCOI
		٠,							ERROR MESSAGES ARE ASSIGNED TO	PALOOI
									PMS (6).	PALOOI
									115 (0)	PALOUI
								DANT KHMANA.	THE PAL PART NUMBER MUST APPEAR	PALOOI
								THE WOULDER,	IN COLUMN ONE OF LINE ONE.	PALOOI
								,	IN COLUMN ONE OF BINE ONE,	PALOOZ
								PIN LIST:	24 SIMBOLIC PIN NAMES MUST APPEAR	PALOUZ
									STARTING ON LINE FIVE.	PALOO2
									SINALING ON BIND 1146.	PALOOZ
								EQUATIONS:	STARTING FIRST LINE AFTER THE	PALOOZ
								200112005.	PIN LIST IN THE FOLLOWING FORMS:	PALOOZ
									TIN BISI IN THE TOBEOWING TORMS.	PALOOZ
									A = 3 *C + J	PALOOZ
									R = 5 · C · U	PALOGE
									A := B*C + D	PALUOZ
										PALCUE
										PALOO
										PALOJE
									ALL CHARACTERS FOLLOWING ": ARE	PALOUS
									IGNORED UNTIL THE NEXT LINE.	PALOUS
									•	PALOU
								1	BLANKS ARE IGNORED.	PALOUS
										PALOOS
								OPERATORS:	( IN HIERARCHY OF EVALUATION )	PALOO
								•	,	PALODS
									; COMMENT FOLLOWS	PALOU
									/ COMPLEMENT	PALODA
									•	PALOO
										PALODA
									: F: XOR (EXCLUSIVE OR)	PALODA
									( ) CUNDITIONAL THREE-STATE	PALODA
									= EQUALITY	PALO04
									:= REPLACED BY (AFTER CLOCK)	PALOO4
									•	PALO04
								FUNCTION	L. H. X. Z. AND C ARE VALID	PALODA
								TABLE:	FUNCTION TABLE VECTOR ENTRIES.	PALOOS
									•	PALOUS
								REFERENCE:	A COMPLETE USERS GUIDE TO	PALOOS
									DESIGNING WITH PALS USING PALASM	PALOGS
									IS PROVIDED IN THE MONOLITAIC	PALOUS
				,					MEMORIES PAL HANDBOOK.	PALOUS

```
FILE: PAL24
               FORTRAN
                            NSC TIME SHARING SERVICES VM/SP HELEASE 2.0
                                                                         PAL00560
C
C
                        SUBROUTINES: INITLZ, GETSYM, INCR, MATCH, IXLATE,
                                                                         PAL00570
С
                                      ECHO, CAT, PINOUT, PLOT, HEX, TWEEK,
                                                                         PAL00580
c
                                      BINK, SLIP, FANTOM, IODC2, IODC4, TEST, PALO0590
                                                                         PAL00600
C
                                     PLOTF, SUMCHK
C
                                                                         PALOD610
c
                                     02/12/82 (VAX/VMS VERSION)
                                                                         PAL00620
                        REV LEVEL:
C
                                      10/13/82 FAULT TESTING
                                                                          PAL00630
C
                                                                          PAL 00640
                                      10/15/82 JEDEC FORMAT
C
                                      BY: I.M. BENGALI
                                                                         PAL00650
C
                                                                         PAL00660
С
                        AUTHORS:
                                     JOHN BIRKNER AND VINCENT COLI
                                                                          PALOO670
C
                                     MONOLITHIC MEMORIES INC.
                                                                          PAI.00680
c
                                                                         PAL00690
                                      1165 EAST ARQUES AVENUE
c
                                     SUNNYVALE, CALIFORNIA 94043
                                                                         PAL00700
                                      (408) 739-3535
                                                                          PAL00713
C
C
                                                                          PAL00720
c
                                     MONOLITHIC MEMORIES TAKES NO
                                                                         PAL00730
                        FINE PRINT:
C
                                     RESPONSIBILITY FOR THE OPERATION
                                                                         PAL00740
c
                                     OR MAINTENANCE OF THIS PROGRAM.
                                                                         PAL00750
                                     THE SOURCE CODE AS PRINTED HERE
C
                                                                         PAL00760
C
                                      PRODUCED THE OBJECT CODE OF THE
                                                                         PAL00770
c
                                      EXAMPLES IN THE APPLICATIONS
                                                                         PAL00780
C
                                      SECTION ON A VAX/VMS 11/78J
                                                                         PAL00790
C
                                     COMPUTER AND A NATIONAL CSS IBM
                                                                         PAL00800
C
                                      SYSTEM/370 FORTRAN IV (G).
                                                                         PAL00810
С
                                                                         PAL00820
PAL00840
C
C
                                                                         PAL00850
C*****************************
                                                                         DAI 00870
C
                                                                         PAL00880
C
C
                                                                         PAL00690
      MAIN PROGRAM
c
                                                                          PAL00900
                                                                          PAL00910
      IMPLICIT INTEGER (A-Z)
      INTEGER IPAL (3), INAME (5), REST (72), PATNUM (80), TITLE (80), COMP (80),
                                                                         PAL00920
     ı
              ISYM (8,24), IBUF (8,24), JPROD (80)
                                                                         PAL00930
      LOGICAL LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LFIRST,
                                                                         PAL00940
              LMATCH, LFUSES (40,80), LPHASE (24), LBUF (24), LPROD (80),
                                                                         PAL00950
                                                                          PAL00960
     2
              LSAME, LACT, LOPERR, LINP, LERR, LSA11, LSA01
      INTEGER
                BEL
                                                                          PAL00970
                                                                          PAL00980
      COMMON
             LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR
                                                                          PAL 00990
      COMMON /PGE/ IPAGE(80,200)
      COMMON /LFUSES/LFUSES
                                                                          PAL01000
                                                                          PAL01010
      COMMON /FTEST/ IFUNCT, IDESC, IEND
      COMMON /LUNIT/ PMS, POF, PDF
                                                                          PAL01020
      DATA E/'E'/,O/'O'/,T/'T'/,P/'P'/,B/'B'/,D/'D'/,H/'H'/,S/'S'/,
                                                                          PAL01030
           L/'L'/, N/'X'/, C/'C'/, Q/'Q'/, U/'U'/, F/'F'/, Y/'Y'/
                                                                          PAL01040
      DATA BB/'B'/,CC/'C'/,DD/'D'/,EE/'E'/,FF/'F'/,II/'I'/,NN/'N'/,
                                                                          PAL01050
           OU/'O'/, PP/'P'/, RR/'R'/, SS/'S'/, TT/'T'/, UU/'U'/, JJ/'J'/
                                                                          PAL01060
      DATA BEL/20700000/
                                                                          PAL01070
                                                                          PAL01080
С
                                                                          PAL01090
С
                                                                          PAL01100
С
      ASSIGNMENT OF DATA SET REFERÊNCES
```

```
FILE: PAL24 FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
С
     RPD - PAL DESIGN SPECIFICATION (INPUT)
                                                                                 PAL01110
C·
       ROC - OPERATION CODE (INPUT)
                                                                                 PAL01120
С
       POF - ECHO, PINOUT, TEST, AND PLOT (OUTPUT)
                                                                                 PAL01136
С
       PDF - HEX AND BINARY FORMAT PROGRAM TAPES (OUTPUT)
                                                                                 PAL01140
С
      PMS - PROMPTS AND ERROR MESSAGES (OUTPUT)
                                                                                 PAL01150
      WRITE (6, 3)
                                                                                 PAL01160
     3 FORMAT(/, PALASH VERSION 1.5 1)
                                                                                 PALU1176
       WRITE (6, 1)
                                                                                 PAL01180
     1 FORMAT (/, WHAT 15 THE LOGICAL UNIT NUMBER FOR OUTPUT (6) ?: 1)
                                                                                 PAL01190
       READ (5, 2) LUN
                                                                                 PAL01200
    2 FORMAT (I4)
                                                                                 PALO1210
       RPD=1
                                                                                 PAL01220
       Roc=5
                                                                                 PAL01230
      POF=6
                                                                                 PAL01240
      POF=6
                                                                                 PAL01250
      PMS=10
                                                                                 PAL01260
      IFUNCT=0
                                                                                 PAL01270
     · IDESC=U
                                                                                 PAL01280
      INITIALIZE LSAME AND LACT TO FALSE (ACTIVE HIGH/LOW ERROR)
                                                                                 PAL01290
      LSAME=.FALSE.
                                                                                 PAL01300
      LACT= FALSE.
                                                                                 PAL01310
C
      INITIALIZE LOPERR TO FALSE (OUTPUT PIN ERROR)
                                                                                 PALO1320
      LOPERR = , FALSE.
                                                                                 PAL01330
                                                                             PAL01340
      READ IN FIRST 4 LINES OF PAL DESIGN SPECIFICATION
      READ (RPD, 10) IPAL, INAME, KEST, PATNUM, TITLE, COMP
                                                                                PALO1350
- 10 FORMAR (3A1,5A1,72A1,/,80A1,/,80A1,/,80A1)
                                                                                 PAL01360
      READ IN PIN LIST (LIAZ 5) THROUGH THE END OF THE PAL DESIGN
                                                                                 PAL01370
С
С
       SPECIFICATION
                                                                                 PAL01380
      DO 15 J=1,200
                                                                                 PAL01390
           READ (HPD, 11, END=16) (IPAGE (I, J), I=1,80)
                                                                                 2AL01400
           FORMAT (80A1)
   11
                                                                                 PAL01410
С
                                                                                 PAL01420
           CHECK FOR 'FUNCTION TABLE' AND SAVE ITS LINE NUMBER
           IF(
                   IFUNCA. EQ.O . AND. IPAGE (1, J) . EQ. FF. AND.
                                                                                PAL01430
               IPAGE(2, 1). E2. UU. AND. IPAGE(3, 1). EQ.NN. AND. IPAGE(4, 1). E2. CC. AND. IPAGE(5, 1). E2. TI. AND. IPAGE(0, 1). E2. II. AND. IPAGE(7, 1). E2. OO. AND. IPAGE(3, 1). E2. NN. AND. IPAGE(10, 1). EQ. TI. AND.
                                                                                PAL01440
     2
                                                                                PAL01450
                                                                             2 ALO 1460
     3
                                                                               PAL01470
     u
               IPAGE(12,J), EQ. BB, AND, IPAGE(14,J), EQ. EE ) IFUNCT=J
     5
                                                                                 PAL01480
           CHECK FOR 'DESCRIPTION' AND SAVE ITS LINE NUMBER
                                                                                 PAL01490
                    IDESC.E2.0 .AND.IPAGE(1,J).EQ.DD.AND.
                                                                                 PAL01500
               IPAGE(2,J). EQ. EE. AND. IPAGE(3,J). EQ. SS. AND.
     1
                                                                                PAL01510
     2
               1PAGE (4, J) . EQ.CC. AND. IPAGE (5, J) . EQ.RR. AND.
               1PAGE (4, J) . EQ. CU. AND. IFROE (7, J) . EQ. PP. AND.

IPAGE (6, J) . EQ. II. AND. IPAGE (7, J) . EQ. II. AND.
                                                                                 PAL01520
                                                                                 PAL01530
     L
                                                                                 PAL01540
               IPAGE(10, J) . Ev. OU. AND. IPAGE(11, J) . EQ. NN ) IDESC = J
                                                                                 PAL01550
   15 CONTINUE
                                                                                 PAL01560
С
      SAVE THE LAST LINE NUMBER OF THE PAL DESIGN SPECIFICATION
                                                                                 PAL01570
   16 IEND=J-1
                                                                                 PAL01580
      CALL INITLE (INAME, ITYPE, LFUSES, IC, IL, IBLOW, IPCTR)
                                                                                 PAL01590
C
      PRINT ERROR MESSAGE FOR INVALID PAL PART TYPE
                                                                                 PAL01600
      IF (ITYPE.NE.O) GO TO 17
                                                                                 PAL01610
      WRITE (PMS, 16) IPAL, INAME
                                                                                 PAL01624
   18 FORMAT (/, PAL PART TYPE ', 3A1, 5A1, ' IS INCORRECT')
                                                                                 PAL01630
      STOP
                                                                                 PAL01640
C
      GET 24 PIN NAMES
                                                                                PAL01650
```

```
FILE: PAL24
                FORTRAN A
                               NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
   17 DO 20 J=1,24
                                                                                 PAL01660
   20
           CALL GETSYM (LPHASE, ISYM, J, IC, IL)
                                                                                 PALO 1670
           IF (, NOT, (LEQUAL, OR, LLEFT, OR, LAND, OR, LOR, OR, LRIGHT)) GO TO 24
                                                                                 PALO 1680
               WRITE (PM5, 23)
                                                                                 PALO 1690
   23
               FORMAT (/, ' LESS THAN 24 PIN NAMES IN PIN LIST')
                                                                                 PAL01700
                                                                                 PAL01713
   24 ILE=IL
                                                                                 PALO 1720
      BYPASS FUSE PLOT ASSEMBLY IF HAL (H IN LINE 1. COLUMN 1)
                                                                                 PALO 1730
      IF ( IPAL (1) . EQ. H ) GO TO 108
                                                                                 PAL01740
   25 CALL GETSYM(LBUF, IBUF, 1, IC, IL)
                                                                                 PALO 1750
           IF (.NOT.LEQUAL) GO TO 25
                                                                                 PAL01760
                                                                                 PAL01770
           ILL=IL
           CALL MATCH (IMATCH, IBUF, ISYM)
                                                                                 PAL01780
                                                                                 PAL01790
           IF (INATCH, EQ.O) GO TO 100
                                                                                 PAL0 1800
C
           CHECK FOR VALID POLARITY (ACTIVE LOW)
                                                          LBUF(1)).OR.
                                                                                 PAL01810
                             LPHASE (IMATCH)) . AND. (
                                                                                 PAL0 1820
                       (.NOT.LPHASE(IMATCH)), AND. (.NOT.LBUF(1)))
                                                                                 PALUTSS
           IF ( ITYPE.NE. b. AND. (LSAME) ) LACT=.TRUE.
           CHECK FOR VALID DUTPUT PIN
                                                                                 PALO 1840
C
  . 29
           IF ( (ITYPE.EQ. 1. OR. ITYPE.EQ. 7. OR. ITYPE. EQ. 3. OR. ITYPE. EQ. 9. OR. PALO 1850
                 ITYPE, EQ. 10) . AND. (IMATCH.LT. 14. OR. IMATCH.GT. 23) )
                                                                                 PAL01860
     2
                LOPERR=.TRUE.
                                                                                 PAL01870
           IF( (ITYPE.EQ.2.OR.ITYPE.EQ.11.OR.ITYPE.EQ.12.OR.ITYPE.EQ.13
                                                                                 PALO 1880
      ١
                 .OR.ITYPE.EQ. 14) .AND. (IMATCH.LT. 15.OR.IMATCH.GT. 22) ).
                                                                                 PALO 1890
     2
                LOPERR= TRUE .
                                                                                 PAL01900
                                                                                 PAL01910
           IF(
                ITYPE, EQ. 3, AND. (IMATCH, LT. 16, OR, IMATCH, GT. 21) )
                                                                                 PALO 1920
      ł
                LOPERR= TRUE.
           IFC
                ITYPE, EQ. 4. AND. (IMATCH, LT. 17. OR. IMATCH, GT. 20) )
                                                                                 PAL01930
                                                                                 PAL01940
                LOPERR= . TRUE.
           IF ( (ITYPE, EQ. 5. OR, ITYPE, EQ. 6), AND,
                                                                                 PAL01950
                (IMATCH.LT. 18.OR.IMATCH.GT. 19) ) LOPERR=.TRUE.
                                                                                 PAL01960
                                                                                 PAL01970
           IF ( (LACT) .OR. (LOPERR) ) GO TO 100
           188PRO=(23-IMATCH) #8 + 1
                                                                                 PALO 1980
c
           START PALZOCI ON PRODUCT LINE 32 (189PRO=33)
                                                                                 PAL01990
           IF (INAME (3) .EQ.C) 188PRO=33
                                                                                 PALOZOGO
           IC=0
                                                                                 PAL02010
   30
             CALL INCR (IC, IL)
                                                                                 PALOZOZO
             If ( NOT. (LEQUAL, OR, LLEFT) ) GO TO 30
                                                                                 PALOZO30
             LPROD (I88PRO) = . TRUE.
                                                                                 PAL02040
             IF (.NOT.LLEFT) CALL SLIP (LFUSES, 188PRO, ITYPE, IBLOW)
                                                                                 PAL02050
                                                                                 PAL02060
           00 70 I8PRO=1,16
               IF ( (LXOR) . AND . 18 PRO . NE . 3 ) GO TO 70
                                                                                 PAL02070
                                                                                 PAL02080
               IPROD = 188PRO + 18PRO - 1
               LPROD (IPROD) = . TRUE.
                                                                                 PAL02090
               LFIRST = . TRUE .
                                                                                 PAL02100
   50
                                                                                 PALO 2110
                 ILL=IL
                                                                                 PAL02120
                 CALL GETSYM (LBUF, IBUF, 1, IC, IL)
                 CALL MATCH (IMATCH, IBUF, ISYM)
                                                                                 PALOZIJO
c
                                                                                 PAL02140
                 CHECK FOR INVALID INPUT PIN
                 IF ( ITYPE.EQ. 1, AND. (INATCH.GE. 14. AND. INATCH.LE. 23) )
                                                                                 PAL02150
      1
                      LINF= TRUE.
                                                                                 PAL02160
                 IF ( ITYPE, EQ. 2, AND, (INATCH, GE, 15, AND, INATCH, LE, 22) )
                                                                                 PAL02170
                                                                                 PAL02180
     1
                      LINP=.TRUE.
                 IF ( ITYPE.EQ. 3. AND. (IMATCH.GE. 16. AND. IMATCH.LE. 21) )
                                                                                 PAL02190
      1
                      LINP= TRUE.
                                                                                 PAL02200
```

```
FILE: PAL24
                FORTRAN A
                             NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
                 IF ( ITYPE, EQ. 4. AND. (IMATCH, GE. 17. AND. IMATCH, LE. 20) )
                                                                               PAL02210
                      LINP=.TRUE.
                                                                               PAL0 2 220
                                                                               PAL02230
                 IF ( ITYPE, EQ. 5. AND. (IMATCH, EQ. 18. OR, IMATCH, EQ. 19) )
                      LINP= .TRUE.
                                                                               PAL02240
                 IF ( ITYPE, EQ. 6. AND. (IMATCH, EQ. 18. OR. IMATCH, EQ. 19) )
                                                                               PAL0 2250
                                                                               PALOZZED
                      LINP= TRUL.
                 IF ( ITYPE, EQ. 7. AND. (IMATCH, EQ. 14. OR. IMATCH, EQ. 23) )
                                                                               PAL02270
                      LINF= TRUE.
                                                                               PALU2280
                                                                               PAL02290
                 IF ( ITYPE, EQ. 8. AND. (IMATCH, EQ. 1. OR, IMATCH, EQ. 13) )
                                                                               PAL02300
                      LINF= TRUE.
                 IF ( ITYPE, EQ. 9., AND. (INATCH, EQ. 1, OR, IMATCH, EQ. 13) )
                                                                               PAL02310
                      LINP= TRUE.
                                                                               PAL02320
                 "IF ( LTYPE, EQ. 10., AND. (IMATCH, EQ. 1, OR, IMATCH, EQ. 13) )
                                                                               PAL02330
                                                                               PAL02340
                      LINP= . THUE.
                 IF ( ITYPE, EQ. 11. AND. (INATCH, EQ. 15. OR, IMATCH, EQ. 22) )
                                                                               PALO2350
     ١
                                                                               PALC2360
                      LINP= . TRUE.
                                                                               PALO2370
                 IF ( ITYPE.GE. 12. AND. (IMATCH. EQ. 1. OR. IMATCH. EQ. 13) ) :
                                                                               PAL02380
                      LINP= TRUE.
                                                                               PAL02390
                 ILL=IL
                 IF (LINP) GO TO 100
                                                                               PA1.02400
                                                                               PAL02410
                 IF (IMATCH.EQ. 0) GO TO 100
                                                                               PAL02420
                 IF (IMATCH.EQ. 12) GO TO 64
                 IF (.NOT.LFIEST) GO TO 58
                                                                               PAL02436
                      LFIRST= . FALSE.
                                                                               PAL0 2440
                      DO 56 I=1,40
                                                                              PAL02450
                          IBLOW = IBLOW + 1
                                                                               PAL02460
   56
                          LFUSES (I, IPROD) = . TRUE.
                                                                               PAL02470
                 CALL IXLATE (IINPUT, LPHASE, IMATCH, LBUF, ITYPE)
   58
                                                                               PAL02480
                 IF (IINPUT.LE.J) GO TO 60
                                                                               PAL02490
                 IBLOW = IBLOW - 1
                                                                               PAL02500
                                                                               PAL02510
                 LFUSES (IINPUT, 1PROD) = . FALSE.
                 CALL PLOT (LBUF, IBUF, LFUSES, IPROD, TITLE, .FALSE., ITYPE,
                                                                               PAL02520
                            LPROL, TOP, IBLOW)
                                                                               PALU2530
   60
                 IF (LAND) GO TO 50
                                                                               PAL02540
   64
                 IF (.NOT.LRIGHT) GO TO 68
                                                                               PAL02550
   66
                 CALL INCR(IC.IL)
                                                                               PALO2560
                 IF (. NOT. LEQUAL) GO TO 66
                                                                               PAL02570
               IF ( .NOT. (LOR.OR.LEQUAL) ) GO TO 74
   68
                                                                               PAL02580
   70
               CONTINUE
                                                                               PAL02590
                                                                            PAL02600
   74
           ILL=IL
           CALL GETSYM (LBUF, IBUF, 1, IC, IL) .
                                                                               PAL02610
                                                                              PAL02620
           IF (LLEFT, OR, LEQUAL) GO TO 28
  100 IF ( ILL.EQ.IFUNCT.OR.ILL.EQ.IDESC.OR.ILL.EQ.IEND ) GO TO 102
                                                                               PAL02630
С
                                                                               PAL02640
      PRINT AN ERROR MESSAGE FOR AN UNRECOGNIZABLE SYMBOL
                                                                               PAL02650
      ILERR=ILL+4
                                                                               PAL02660
      WRITE (PMS, 99) BEL
   99 FORMAT ( ' , A 1)
                                                                               PAL02670
      WRITE (PMS, 101) (IBUF (1, 1), I=1, 8), ILERR, (IPAGE (I, ILL), I=1, 60)
                                                                               PAL02680
  101 FORMAT (/, * ERROR SYMBOL = *, 8A1, * IN LINE NUMBER *, 13,
                                                                               PAL02690
              /, 1 1,80A1)
                                                                               PAL02700
С
      PRINT AN ERROR MESSAGE FOR ACTIVE HIGH/LOW ERRORS
                                                                               PAL02710
      IF ( (LACT) .AND. (.NOT.LOPERR) ) WRITE (PHS, 103) IPAL, INAME
                                                                             PAL02720
  103 FORMAT (' OUTPUT MUST BE INVERTED SINCE ', 3A1,5A1,
                                                                              PAL02730
              ' IS AN ACTIVE LOW DEVICE')
                                                                               PAL02740
C
      PRINT AN ERROR MESSAGE FOR AN INVALID OUTPUT PIN
                                                                              PAL02750
```

```
FILE: PAL24
                FORTRAN A
                              NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      IF ( (LOPERR) .AND.IMATCH.NE.J ) WRITE (PMS, 105) IMATCH, IPAL, INAME
                                                                               PAL02760
  105 FORMAT ( THIS PIN, NUMBER ',12,  IS AN INVALID OUTPUT PIN',
                                                                               PAL02770
              ' FOR ', 3A 1, 5A 1)
                                                                               PAL02780
C
      PRINT AN ERROR MESSAGE FOR AN INVALID INPUT PIN
                                                                               PAL02790
      IF (LINP) WRITE (PMS, 115) IMATCH, IPAL, INAME
                                                                               PAL02800
  115 FORMAT( THIS WIN NUMBER 1,12, 15 AN INVALID INPUT PIN.
              ' FOR ',3A1,5A1)
                                                                               PAL02820
      STOP
                                                                               PALO2830
  102 CALL THEEK (ITYPE, LFUSES)
                                                                               PAL02840
  108 WRITE (6, 106)
                                                                               PAL0 2850
  106 FORMAT(/, ' OPERATION CODES: ')
                                                                               PALO286U
      WRITE (6, 107)
                                                                               PAL02870
  107 FORMAT (/, ' E=ECHO INPUT O=PINOUT T=SIMULATE
                                                        P=PLOT B=SRIEF',
                                                                               PAL02880
              /, C=CATALOG H=HEX S=SHORT L=BHLF N=BNPF .
                                                                               PAL02890
              /, Q=QUIT F=FAULT TESTING J=JEDEC FORMAT')
                                                                               PAL02900
                                                                               PALO2910
      WRITE (6, 110)
  110 FORMAT (/, ' ENTER OPERATION CODE: ')
                                                                               PAL02920
      READ (ROC, 120) IOP
                                                                               PAL02930
  120 FORMAT (A1)
                                                                               PAL02940
С
      CALL IODC 2
                                                                               PAL02950
      IF (POF.NE.6) WRITE (POF. 125)
                                                                               PAL02960
  125 FORMAT ('1')
                                                                               PAL02970
      IF (IOP. EQ. E) CALL ECHO (IPAL, INAME, REST, PATNÚM, TITLE, COMP)
                                                                               PAL02980
      IF (IOP. EQ. O) CALL PINOUT (IPAL, INAME, TITLE)
                                                                               PAL02990
      IF (IOP. EQ. T) CALL TEST (LPHASE, LBUF, TITLE, IC, IL, ILE, ISYM, IBUF,
                                                                               PAL03000
                          ITYPE, IPCTR, LERR, ISAF, IPCTR1, . FALSE., . FALSE.)
                                                                               PAL03010
      IF (IOP.EO.JJ) CALL PLOTF
                                                                               PAL03020
С
                                                                               PALO 3030
      TSAF=0
                                                                               PALO 304C
      IF (IOP.EV.F) GO TO 200
                                                                               PAL03050
C
                                                                               PAL03060
  135 IF(IOP.EQ.P) CALL PLOT(LBUF, IBUF, LFUSES, IPROD, TITLE, TRUE, , ITYPE, PALO3070
                                LPROD, IOP, IBLOW, IPCTRO)
                                                                               PAL03080
      IF (IOP.EQ.B) CALL PLOT (LEUF, IBUF, LFUSES, IPROD, TITLE, TRUE., ITYPE, PALO3090
     1
                                LPROD, IOP, IBLOW, IPCTRO)
                                                                               PAL03100
      IF (IOP, EQ. H) CALL HEX (LFUSES, H)
                                                                               PAL03110
                                                                             PAL03120
      IF (IOP. EQ. S) CALL HEX (LFUSES, S)
      IF (IOP. EQ. L) CALL BINR (LFUSES, H. L)
                                                                               DALO3130
      IF (IOP. EQ. N) CALL BINR (LFUSES, P, N)
                                                                               PALO3140
      IF (IOP. EQ. C) CALL CAT
                                                                               PALO 3 150
C
      CALL IODC4
                                                                               PAL03160
      IF (IOP, NE, Q ) GO TO 108
                                                                               PALO 3 170
      STOP
                                                                               PALO3180
С
                                                                               PAL03190
   SETTING THE PARAMETERS FOR THE SAO/SAI TESTS
                                                                               PAL03200
  200 IPCTR=0
                                                                               PAL03210
      CALL TEST (LPHASE, LBUF, TITLE, IC, IL, ILE, ISYM, IBUF, ITYPE, IPCTR,
                                                                               PAL03220
                 LERR, ISAF, IPCTR1, FALSE., FALSE.)
                                                                               PAL03230
      IPCTRO=IPCTR
                                                                               PAL03240
   LOOPING FOR SAI TEST
                                                                               PAL03250
      DO 210 IPCTR1=1, IPCTR0
                                                                               PAL03260
      LSAII= TRUE.
                                                                               PAL03270
      CALL TEST (LPHASE, LBUF, TITLE, IC, IL, ILE, ISYM, IBUF, ITYPE, IPCTR,
                                                                               PAL03280
                 LERR, ISAF, IPCTR1, LSA11, . FALSE.)
                                                                               PAL03290
  210 CONTINUE
                                                                               PAL03300
```

```
FILE: PAL24
               FORTRAN A
                           NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      ISA 1=ISAF
                                                                             PALO 3310
                                                                             PAL03320
    LOOPING FOR SAO TEST
      DO 215 IPCTR1=1, IPCTRO
                                                                             PAL03330
                                                                             PAL03340
      LSAOI=. THUE.
      CALL TEST (LPHASE, LBUF, TITILE, IC, IL, ILE, ISYM, IBUF, 114PE, IPCTR,
                                                                             PAL03350
                                                                             PAL0 3360
     1
                 LERR, ISAF, IPCTR1, . FALSE., LSAO1)
  215 CONTINUE
                                                                             PAL03370
                                                                             PAL03380
      ISAU=ISAF-ISA1
                                                                             PAL03390
      IFAULT = (ISAF * 100) / (2 * IPCTRO)
                                                                             PAL03400
      WRITE (POF, 220) ISA1
  220 FORMAT (/, NUMBER OF STUCK AT ONE (SAI) FAULTS ARE = 1, 13)
                                                                             PAL03410
      WRITE (POF, 225) ISAO
                                                                             PAL03420
  225 FORMAT (/, NUMBER OF STUCK AT ZERO (SAU) FAULTS ARE = 1, 13)
                                                                             PAL03430
      WRITE (POF, 230) IFAULT
                                                                             PAL03440
                                                             =1 [3,1%1,//)
  230 FORMAT (/, PRODUCT
                            TERM
                                    COVERAGE
                                                                            PAL03450
      GO TO 135
                                                                             PAL03460
c
                                                                             PAL03470
                                                                             PAL03480
      END
                                                                             PAL03490
c
C********************************
                                                                             PAL03510
С
                                                                             PAL03520
C THIS SUBROUTINE GENERATES JEDEC FORMATTED OUTPUT FOR INTERFACING
                                                                             PAL03530
 WITH DATA I/O PROGRAMMER
                                                                             PAL03540
      SUBROUTINE PLOTF
                                                                             PALU3550
      IMPLICIT INTEGER (A-Z)
                                                                             PAL03560
                                                                             PAL03570
      LOGICAL LFUSES (40,80)
      INTEGER IPBUF (40) .ZERO.GNE
                                                                             PAL03580
      INTEGER ISUM (4) , IADR, STX, ETX, IDEC (4) , IPT, IINP, J1, J2
                                                                             PAL03590
                                                                             PAL03600
      INTEGER IDECIO (4), ISUNV (4), ISUNIO (4), BUFIO (46)
                                                                             PAL03610
      COMMON /LUNIT/PMS, POF, PDF
                                                                             PAL03620
      COMMON /IPT/IPT
                                                                             PAL03630
      COMMON /LFUSES/LFUSES
                                                                             PAL03640
      CONMON /SUM/ISUM, IDEC, IPBUF, BUFIO
                                                                             PAL03650
      DATA ZERO/'O'/, ONE/'I'/
                                                                             PAL03660
      IADR=0
                                                                             PAL03670
      STX = 2
      ETX = 3
                                                                             PAL03680
                                                                             PAL03690
      ISUM (2) =0
      ISUM (4) = 230
                                                                             PAL03700
      WRITE (PDF, 10) STX
                                                                             PAL03710
   10 FORMAT (* ', A1, **FO**)
                                                                             PAL03720
                                                                             PAL03730
      DO 300 IPT=1,80
      DO 50 IINP=1,40
                                                                             PAL03740
      IF (LFUSES (IINP, IPT)) IPBUF (IINP) =ONE
                                                                             PALO 3750
                                                                             PAL03760
      IF (.NOT. (LFUSES (IINP, IPT))) IPBUF (IINP) = ZERO
   50 CONTINUE
                                                                             PAL03770
      IF (LFUSES (1, IPT)) GO TO 100
                                                                             PAL03780
      IF (.NOT.LFUSES (2, IPT)) GO TO 250
                                                                             PAL03790
  100 IDEC (4) = IADE
                                                                             PAL03800
      DO 150 J=1.3
                                                                             PAL03810
      J1=5-J
                                                                             PAL03820
                                                                             PAL03830
      J2=4-J
      IDEC(J2) = IDEC(J1)/10
                                                                             PAL03840
                                                                             PAL03850
      IDEC(J1) = IDEC(J1) - 10 * IDEC(J2)
```

```
FILE: PAL24
                               NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
                FORTRAN A
      IDECIO (J1) = ICONV (IDEC (J1))
                                                                               PAL03860
                                                                               PAL03870
  150 CONTINUE
                                                                               PAL03880
      IDECIO(1) = ICONV (IDEC(1))
                                                                               PAL03890
      CALL SUMCHK
      WRITE (PDF, 201) IDECTO, IPBUF
                                                                               PAL03900
  201 FORMAT (' L', 4A1, ' ', 10 (4A1, ' '), '*')
                                                                               PAL03910
  250 IADR=IADR+40
                                                                               PAL03920
  300 CONTINUE
                                                                               PAL03930
      ISUMIO (1) = ICONV (ISUM (2)/16)
                                                                               PAL03940
      ISUM (2) = MOD (ISUM (2), 16)
                                                                               PALO3950
      ISUMIO(2) = ICONV(ISUM(2))
                                                                               PAL03960
      ISUMIO(3) = ICONV (ISUM(4) /16)
                                                                               PAL03970
      ISUM (4) = MOD (ISUM (4), 16)
                                                                               CECLOIAN
      ISUNIO (4) = ICONV (ISUM (4))
                                                                               PALO3990
      WRITE (PDF, 400) ETX, ISUMIO
                                                                               PAL04000
  400 FORMAT(* #1, A1, 4A1, **1,/)
                                                                               PAL04010
      RETURN
                                                                               PAL04020
      END
                                                                               PAL04030
c
                                                                               PALO4040
C
                                                                               PAL04050
C
                                                                               PAL04060
      SUBROUTINE SUNCHK
                                                                               PAL04070
                                                                               PALÓ4080
      IMPLICIT INTEGER (A-Z)
      LOGICAL LEUSES (40,80)
                                                                               PAL04690
                                                                               PAL04100
      INTEGER IPBUF (40), BUFIO (40)
      INTEGER ISUM (4), IDEC (4)
                                                                               PAL04110
      COHMON /IPT/IPT
                                                                               PAL04120
                                                                               PAL04136
      COMMON /LFUSES/ LFUSES
      COMMON /SUM/ ISUM, IDEC, IPBUF, BUFIO
                                                                               PAI.04140
      DO 50 J=1.40
                                                                               PAL04150
      IF (LFUSES (J, IPT)) BUFIO (J) = 49
                                                                               PAL04 160
      IF (.NOT.LPUSES (J, IPT)) BUFIO (J) = 46
                                                                               PAL04170
      ISUM(4) = ISUM(4) + BUFIO(J)
                                                                               PAL04180
                                                                               PAL04190
      IF (ISUM (4), GE, 256) ISUM (2) = ISUM (2) +1
                                                                               PAL04200
      ISUM(4) = MOD(ISUM(4), 256)
   50 CONTINUE
                                                                               PAL04210
                                                                               PAL04220
      DO 100 J=1,4
      ISUM (4) = LSUM (4) + LDEC (J) +48
                                                                               PAL04230
                                                                               PAL04240
      IF (ISUM (4) .GE.256) ISUM (2) = ISUM (2) +1
      ISUM(4) = MOD(ISUM(4), 256)
                                                                               PAL04250
  100 CONTINUE
                                                                               PAL04260
      ISUM (4) = ISUM (4) + 173
                                                                               PAL04270
      ISUM (2) = ISUM (2) +1
                                                                               PAL04280
      IF (ISUM (4) . GE. 256) ISUM (2) = ISUM (2) +1
                                                                               PAL04290
      ISUM(4) = MOD(ISUM(4), 256)
                                                                               PAL04300
      RETURN
                                                                               PALO4310
      END
                                                                               PAL04320
                                                                               PAL04330
PAL04340
      INTEGER FUNCTION ICONV(K)
                                                                               PAL04350
      IMPLICIT INTEGER (A-2)
                                                                               PAL04360
      DATA A/101/, B/111/, C/121/, D/131/, E/141/, F/151/, G/161/, H/171/
                                                                               PAL04370
      DATA I/'8'/, J/'9'/, X/'A'/, L/'B'/, M/'C'/, N/'D'/, O/'E'/, P/'F'/
                                                                               PAL04380
      IF (K.EQ.0) ICONV=A
                                                                               PAL04390
                                                                               PAL04400
      IF (K. EQ. 1) ICONV=B
```

```
FILE: PAL24
                FORTRAN A
                              NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      IF (K.EQ.2) ICONV=C
                                                                              PAL04410
      IF (K.EQ. 3) ICONV=L
                                                                              PAL04420
      IF (K.EQ.4) ICONV=E
                                                                              PAL04430
      IF (K.EQ.5) ICONV=F
                                                                              PAL04440
      IF (K.EQ.6) ICONV=G
                                                                              PAL04450
      IF (K.EQ.7) ICONV=H
                                                                              PAL04460
      IF (K.EQ.8) ICONV=1
                                                                              PAL04470
      IF (K.EQ.9) ICONV=J
                                                                              PAL04480
      IF (K.EQ.10) ICONV=X
                                                                              PAL04490
      1F(K.EQ. 11) ICONV=L
                                                                              PALC450C
      IF (K. EQ. 12) ICONV=M
                                                                              PAL04510
      IF (K.EQ.13) ICONV=N
                                                                              PALC4520
      IF (K.EQ. 14) ICONV=0
                                                                              PALO4530
      IF (K, EQ. 15) ICONV=P
                                                                              PAL04540
      RETURN
                                                                              PAL04550
                                                                              PAL04560
C***************
                                                                              PAL04570
c
                                                                              PAL04580
c
                                                                              PAL04590
      SUBROUTINE INITLZ (INAME, ITYPE, LFUSES, IC, IL, IBLOW, IPCTR)
                                                                              PAL04600
C
      THIS SUBROUTINE INITIALIZIES VARIABLES AND MATCHES PAL PART
                                                                              PAL04610
c
       NUMBER WITH ITYPE
                                                                              PAL04626
      IMPLICIT INTEGER (A-Z)
                                                                              PAL04630
                                                                              PAL04640
      INTEGER INAME (5), INFO (6, 14)
      LOGICAL LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LFUSES (40,80), PALO4650
               LMATCH, LXOR
                                                                              PAL04660
      COMMON LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR
                                                                              PAL04670
      COMMON /PGE/ IPAGE(80, 200)
                                                                              PAL04680
      DATA INFO/
                                                                              PAL04690
            11, 21, L1, 11, 101, 1, 11, 101, 1, 11, 181, 1 1, 2,
                                                                              PAL04700
     1
     2
                                                                              PAL04710
            111,161,111,161,1 1,3,
     3
                                                                              PAL04720
     4
            111,181,161,141,1 1,4,
                                                                              PAL04730
     5
            121,101,11,121,1 1,5,
                                                                              PAL04740
            121,101,101,111,1 1,6,
     6
                                                                              PAL04750
            121,101,111,111,101,7,
     7
                                                                              PAL04760
     8
            121, 101, 1X1, 111, 101, 8,
                                                                              PAL04770
            121,101,1X1,181,1 1,9,
     9
                                                                              PAL04780
            121,101,1X1,141,1 1,10,
                                                                              PAL04790
     A
     В
            '2','0','L','8',' ',11,
                                                                              PAL04800
            121,101,181,181,1 1,12,
     C
                                                                              PAL04810
            121,101,1R1,161,1 1,13,
     D
                                                                              PAL04820
            +21,101,181,141,1 1,14/
                                                                              PAL04830
C.
      INITIALIZE LEUSES ARRAY (FUSE ARRAY)
                                                                              PALO4840
      DO 20 J=1,80
                                                                              PAL04850
          DO 20 I=1,40
                                                                              PAL04860
   20
           / LFUSES (I, J) = . FALSE.
                                                                              PAL04870
C
      INITIALIZE IBLOW (NUMBER OF FUSES BLOWN)
                                                                              PAL04880
      IBLOW=0
                                                                              PAL04890
      IPCTR=0
                                                                              PAL04900
С
      INITIALIZE IC AND IL (COLUMN AND LINE POINTERS)
                                                                              PAL04910
      TC = 0
                                                                              PAL04920
      IL=1
                                                                              PAL04930 .
      INITIALIZE ITYPE (PAL PART TYPE)
С
                                                                              PAL04940
```

PAL04950

ITYPE=0

```
FILE: PAL24
                            NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
               FORTRAN A
c
      ITYPE IS ASSIGNED THE FOLLOWING VALUES FOR THESE PAL TYPES:
                                                                        PAL04960
C
      PAL12L10 = 1
                      PAL1418 = 2
                                      PAL1616 = 3
                                                      PAL1314 =
                                                                        PAL04970
c
      PAL20L2 =
                  ς
                      PAL2GCT
                                 દ
                                      PAL20LID =
                                                  7
                                                      PAL20X10 =
                                                                  8
                                                                        PAL04980
C
      PAL2CX8
              =
                  Q
                      PAL20X4
                              = 10
                                      PAL2018 = 11
                                                      PAL2CR8 = 12
                                                                        PAL04990
      PAL2086 = 13
C
                      PALZOR4
                                 14
                                                                         2AL05000
      DO 40 J=1.14
                                                                        PAL05010
         LMATCH= . TRUE .
                                                                        PAL05020
         DO 30 I=1.4
                                                                        PAL05030
   30
            IF (INAME (I) . NE. INFO (i, J)) LMATCH=. FALSE.
                                                                        PAL05040
         IF (LMATCH) ITYPE=INFO (6, J)
                                                                        PAL05050
         IF (LMATCH) GO TO 50
                                                                        PAL05060
   40 CONTINUE
                                                                        PAL05070
      IF (ITYPE, EQ. 0) RETURN
                                                                        PAL0508C
   50 CALL INCR (IC. IL)
                                                                        PAL05090
      RETURN
                                                                        PAL 05 100
      END
                                                                        PALOS 110
С
                                                                        PAL05120
PAL05140
      SUBROUTINE GETSYM (LPHASE, ISYM, J, IC, IL)
                                                                        PALO5 150
      THIS SUBROUTINE GETS THE PIN NAME, / IF COMPLEMENT LOGIC, AND
c
                                                                        PAL05163
      THE FOLLOWING OPERATION SYMBOL IF ANY
C
                                                                        PALOS 170"
      IMPLICIT INTEGER (A-Z)
                                                                        PAL05180
      INTEGER ISYM (8,24)
                                                                        PAL05190
      LOGICAL LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LPHASE (24) PALO5200
      COMMON LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR
                                                                        PAL05210
      COMMON /PGE/ IPAGE (80, 200).
                                                                       PALOSZZÚ
      DATA IBLANK/ 1/
                                                                        PALOS230
      IF( .NOT. (LLEFT.OR.LAND.OR.LOR.OR.LEQUAL.OR.LRIGHT) ) GO TO 10
                                                                        PAL05240
      CALL INCR (IC, IL)
                                                                        PAL05250
   10 LPHASE (J) = (.NOT.LSLASa)
                                                                        PAL05260
      IF (LPHASE (J)) GO TO 15
                                                                        PAL05270
      CALL INCR (IC, IL)
                                                                        PAL05280
   15 DG 20 T=1,8
                                                                        PAL05290
   20
          ISYM(I.J) = IBLANK
                                                                        PAL05300
   25 DO 30 I=1.7
                                                                        PAL05310
          ISYM(I,J) = ISYM(I+I,J)
                                                                        PAL05326
      ISYM(8, J) = IPAGE(IC, IL)
                                                                        PAL05330
      CALL INCR (IC, IL)
                                                                        PAL05340
      IF ( LLEFT, OR, LBLANK, OR, LAND, OR, LOR, OR, LRIGHT, OR, LEQUAL ) RETURN
                                                                        PALO5350
      GO TO 25
                                                                        PAL05360
      END
                                                                        PAL05370
C
                                                                        PAL05380
C
                                                                        PAL05400
      SUBROUTINE INCR (IC, IL)
                                                                        PAL05410
c
      THIS SUBROUTINE INCREMENTS COLUMN AND LINE POINTERS
                                                                        PAL05420
      BLANKS AND CHARACTERS AFTER "; ARE IGNORED
\mathbf{c}
                                                                        PAL05430
      IMPLICIT INTEGER (A-Z)
                                                                        PAL05440
      LOGICAL LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LXOR1
                                                                        PAL05450
      COMMON LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR
                                                                        PAL05460
      COMMON /PGE/ IPAGE(80,200)
                                                                        PAL05470
     COMMON /LUNIT/ PMS, POF, PDF
                                                                        PAL05480
     DATA IBLANK/' '/, ILEFT/' ('/, IAND/'*'/, IOR/'+'/, COMENT/';'/,
                                                                        PAL05490
              ISLASH/'/', IEQUAL/'='/, IRIGHT/')'/, ICOLON/':'/
                                                                        PAL05500
```

```
FILE: PAL24
             FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
                                                                       PAL05510
      LBLANK = . FALSE.
      LXOR= . FALSE.
                                                                       PAL05520
                                                                       PAL05530
      LXORI=. FALSE.
   10 IC=IC+1
                                                                       PAL05540
                                                                       PAL05550
      IF ( IC.LE.79; AND, IPAGE (IC, IL) . NE, COMENT ) GO TO 30
                                                                       PAL05560
      IL=IL+1
                                                                       PAL05570
      IF (IL.LE. 200) GO TO 20
                                                                       PAL05580
          WRITE (PMS, 15)
                                                                       2AL05590
   15
          FORMAT (/, ' SOURCE FILE EXCEEDS 200 LINES OR MISSING',
                   DESCRIPTION OR FUNCTION TABLE KEY WORD!)
                                                                       PAL05600
                                                                       PAL05610
   20 IC=0
                                                                       PAL05620
      GO TO 13
                                                                       PAL05630
   30 IF (IPAGE (IC, IL) . NE. IBLANK) GO TO 31
                                                                       PAL05640
      LBLANK= TRUE.
                                                                       PAL05650
                                                                       PAL05660
      GO TO 10
   31 IF (IPAGE (IC, IL), NE, ICOLON) GO TO 32
                                                                       PAL05670
                                                                       PAL0568U
      IF (LXOA) GO TO 33
      LXOR1=.TRUE.
                                                                       PAL05690
      GO TO 10
                                                                       PAL05700
   33 LOR=.TRUE.
                                                                       PAL05710
      RETURN
                                                                       PAL05720
   32 IF ( .NUT. (IPAGE (IC. IL) .EU. IOR. AND. (LXOR !) ) GO TO 34
                                                                       PAL05730
      LXOR= .TRUE .
                                                                       PAL05740
      GO TO 10
                                                                       PAL05750
   34 LLEFT = (IPAGE (IC, IL) . EQ. ILEFT)
                                                                       PALU5760
      LAND = (IPAGE(IC, IL), EQ.IAND)
                                                                       PAL05770
      LOB = (IPAGE(IC,IL),EQ,IOR)
                                                                       2XL05780
                                                                       PAL05790
      LSLASH= (IPAGE (IC, IL) . EQ. ISLASH)
      LEQUAL= (LPAGE (IC, IL) . EQ. IEQUAL)
                                                                       DVC91Vd
      LRIGHT = (IPAGE (IC, IL) . EQ. IRIGHT)
                                                                       PAL05810
      RETURN
                                                                       PAL05820
      END
                                                                       PAL05830
c
                                                                       FAL05840
С
                                                                       PAL05860
      SUBROUTINE MATCH (IMATCH, IBUF, ISYM)
                                                                       PAL05870
c
      THIS SUBROUTINE FINDS A MATCH BETWEEN THE PIN NAME IN THE EQUATIONPALOS880
      AND THE PIN NAME IN THE PIN LIST OR FUNCTION TABLE PIN LIST
                                                                      PAL05890
     IMPLICIT INTEGER (A-Z)
                                                                       PAL05900
      INTEGER 18UF (8, 24), ISYM (8, 24)
                                                                       PAL05910
      LOGICAL LMATCH
                                                                       PAL05920
      IMATCH=0
                                                                       PAL05930
      DO 20 J=1.24
                                                                       PAL05940
         LMATCH = . TRUE.
                                                                       2AL05950
         DO 10 I=1.8
                                                                       PAL05960
   10
             LMATCH=LMATCH, AND, (180F (I, 1), EQ. ISYM (I, J))
                                                                       PAL05970
         IF (LMATCH) IMATCH=J
                                                                       PAL05980
   20
         CONTINUE
                                                                       PAL05990
     RETURN
                                                                       PAL06000
                                                                       PAL06010
     END
С
PAL06040
     SUBROUTINE IXLATE (IINPUT, LPHASE, IMATCH, LBUF, ITYPE)
                                                                      PAL06050
```

```
FILE: PAL24
                FORTRAN
                              NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
С
      THIS SUBROUTINE FIRDS A MATCH BETWEEN INPUT PIN NUMBER AND
                                                                              PAL06060
C
       THE INPUT LINE NUMBER FOR A SPECIFIC PAL. ADD 1 TO THE INPUT
                                                                              PAL06070
c
       LINE NUMBER IF THE PIN IS A COMPLEMENT
                                                                              PAL06080
      IMPLICIT INTEGER (A-2)
                                                                              PAL06090
      INTEGER ITABLE (24, 14)
                                                                              PAL06100
      LOGICAL LPHASE (24), LBUF (24)
                                                                              PAL06110
      DATA
               ITABLE/
                                                                              PAL06120
     1 3,1,5,9,13,17,21,25,29,33,37,0,39, 0, 0, 0, 0, 0, 0, 0, 0, 0, 0, 0, 0ALO6130
     2
       3,1,5,9,13,17,21,25,29,33,37,0,39,35, 0, 0, 0, 0, 0, 0, 0, 0, 0, 0, PALO6140
       3,1,5,9,13,17,21,25,29,33,37,0,39,35,31, 0, 0, 0, 0, 0, 0,11,7,0,PAL06150
       3,1,5,9,13,17,21,25,29,33,37,0,39,35,31,27, 0, 0, 0, 0,15,11,7,0,PAL06160
       3,1,5,9,13,17,21,25,29,33,37,0,39,35,31,27,23, 0, 0,19,15,11,7,0,PAL06170
       3, 1, 5, 9, 13, 17, 21, 25, 29, 33, 37, 0, 39, 35, 31, 27, 23, 0, 0, 19, 15, 11, 7, 0, PALO 6 180
       3, 1, 5, 9, 13, 17, 21, 25, 29, 33, 37, 0, 39, 0, 35, 31, 27, 23, 19, 15, 11, 7, 0, 0, PAL06190 0, 1, 5, 9, 13, 17, 21, 25, 29, 33, 37, 0, 0, 39, 35, 31, 27, 23, 19, 15, 11, 7, 3, 0, PAL06200
     7
       0,1,5,9,13,17,21,25,29,33,37,0, 0,33,35,31,27,23,19,15,11, 7,3,0,PAL06210
     A 0,1,5,9,13,17,21,25,29,33,37,0, 0,39,35,31,27,23,19,15,11, 7,3,0,PAL06220
       3,1,5,3,13,17,21,25,29,33,37,0,39,35, 0,31,27,23,19,15,11, 0,7,0,PAL06230
     C 0,1,5,9,13,17,21,25,29,33,37,0, 0,39,35,31,27,23,19,15,11, 7,3,0,PAL06240 D 0,1,5,9,13,17,21,25,29,33,37,0, 0,39,35,31,27,23,19,15,11, 7,3,0,PAL06250
     E 0,1,5,9,13,17,21,25,29,33,37,0, 0,39,35,31,27,23,19,15,11, 7,3,0/PALO6260
      TRUBL=0
      IF( ((
                  LPHASE (IMATCH)) . AND. (. NOT. LBUF(1))) .OR.
                                                                              PAL06280
           ((.NOT. LPHASE (IMAICH)) .AND. (
                                             LBUF(1))) ) IBUBL=1
                                                                              PAL06290
      IINPUT=ITABLE (IMATCH, ITYPE) + IBUBL
                                                                              PAL06300
      RETURN
                                                                              PAL06310
      END
                                                                              PALO6320
С
                                                                              PAL06330
C**
   C
                                                                              PAL06350
      SUBROUTINE ECHO (IPAL, INAME, REST, PATNUM, TITLE, COMP)
                                                                              PAL06360
C
      THIS SUBROUGINE PRINTS THE PAL DESIGN SPECIFICATION INPUT FILE
                                                                              PALO6370
      IMPLICIT INTEGER (A-Z)
                                                                              PAL06380
      INTEGER IPAL (3), INAME (5), REST (72), PATNUM (80), TITLE (80), COMP (80)
                                                                              PAL06390
      COMMON /PGE/ IPAGE (80, 200)
                                                                              PAL06400
      COMMON /LUNIT/ PMS, POF, PDF
                                                                              PAL06410
      COMMON /FTEST/ IFUNCT, IDESC, IEND
                                                                              PALO6420
      DATA IBLANK/ 1/
                                                                              PAL06430
      WRITE (POF, 5) IPAL, INAME, REST, PATNUM, TITLE, COMP
                                                                              PAL06440
    5 FORMAT (/,' ',3x1,5x1,72x1,/,' ',60x1,/,' ',80x1,/,' ',80x1)
                                                                              PAL06450
      DO 20 IL=1, IEND
                                                                              PAL06460
          IC=81
                                                                              PAL06470
   10
          1C=IC-1
                                                                              PAL06480
          IF ( IPAGE (IC. IL) . EU. IBLANK . AND . IC. GT. 1 ) GO TO 10
                                                                              PAL06490
           WRITE (POF, 15) (IPAGE (I, IL), I=1, IC)
                                                                              PAL06500
          FORMAT ( 1,80 A 1)
                                                                              PAL06510
   20 CONTINUE
                                                                              PAL06520
      RETURN
                                                                              PAL06530
      END
                                                                              PAL06540
C
                                                                              PAL06550
C * * *
     C
                                                                              PAL06570
      SUBROUTINE CAT
                                                                              PAL06580
      THIS SUBROUTINE PRINTS THE PALASM CATALOG
С
                                                                              PAL06590
                                                                              PAL06600
      IMPLICIT INTEGER (A-Z)
```

```
FILE: PAL24
              FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      COMMON /LUNIT/ PMS, POF, PDF
                                                                         PAL06610
      WRITE (PMS, 10)
                                                                         PAL06620
   10 FORMAT (/, THIS PALASM ALDS THE USER IN THE DESIGN AND ,
                                                                         PAL06630
               * PROGRAMMING OF THE ! . / . SERIES 24 PAL FAMILY. THE ! .
                                                                         PAL06640
               * FOLLOWING OPTIONS ARE PROVIDED: .
                                                                         PAL06650
     3
                    ECHO (E)
                                 - PRINTS THE PAL DESIGN',
                                                                         PAL06660
               * SPECIFICATION*,
     4
                                                                         PAL06670
            //,'
                    (O) TUORIA
                                 - PRINTS THE PINOUT OF THE PAL!,
                                                                         PAL06680
                    SIMULATE (T) - EXERCISES THE FUNCTION TABLE!
                                                                         PALOS690
     7
               ' VECTORS IN THE LOGIC',/,'
                                                                         PAL06700
               ' EQUATIONS AND GENERATES TEST VECTORS',
                                                                         PAL06710
            11.
                                 - PAINTS THE ENTIRE FUSE PLOT')
                    5F01 (5)
                                                                         PAL06720
      WRITE (PMS, 20)
                                                                         FAL06730
   20 FORMAT(/, 1
                                 - PRINTS ONLY THE USED PRODUCT LINES', PALO6740
                    BRIEF (B)
                 OF THE FUSE PLOT'./,'
     ١
                                                          PHANTOM'.
                                                                         PAL06750
               * FUSES ARE UMITTED*,
                                                                         PAL06760
     ž
            //,1
                    JEDEC (J)
                                 - GENERATES FUSE OUTPUT FOR DATA I/O', PALO6770
               PROGRAMMERS ..
     4
                                                                         PALU6780
            11.1
     5
                    dex (H)
                                 - GENERATES HEX PROGRAMMING FORMAT'.
                                                                         PAL06790
            //.'
                    SHORT (S)
                                 - GENERATES HEX PROGRAMMING FORMAT',
     6
                                                                         PAL06800
            //,'
     7
                                 - GENERATES BHLF PROGRAMMING FORMAT .
                    SHLF (L)
                                                                         PAL06810
                                - GENERATES BNPF PROGRAMMING FORMAT!,
            //,'
                    SNPF (A)
     í
                                                                         PAL06820
                    CATALOG (C) - PRINTS THE PALASH CATALOG',
            //,1
     9
                                                                         PAL06830
            11,1
                                 - EXIT PALASM',
     A
                    (5) LIOP
                                                                         PAL06840
            11.1
                                - FAULT TESTING!)
                    FAULT (F)
                                                                         PAL05850
     B
     RETURN
                                                                         PAL06860
      END
                                                                         PAL06870
С
                                                                         PA1.06880
С
                                                                         PAL06900
      SUBROUTINE PINOUT (IPAL, INAME, TITLE)
                                                                         PAL06910
C
      THIS SUBROUTINE PRINTS THE PINOUT OF THE PAL
                                                                         PAL06920
      IMPLICIT INTEGER (A-Z)
                                                                         PAL06930
      INTEGER 1PAL (3), INAME (5), TITLE (80), PIN (12, 24), IIN (8, 2)
                                                                         PAL06940
      COMMON /PGE/ IPAGE(80,200)
                                                                         PAL06950
      COMMON /LUNIT/ PMS, POF, PCF
                                                                         PAL06960
      DATA IBLANK/ 1/, ISCAR/ +1/
                                                                         PAL06970
      00 10 J=1,24
                                                                         PAL06980
                                                                         PAL06990
          00 5 1=1,12
                                                                         PAL07000
              PIN(I,J) = IBLANK
   10 CONTINUE
                                                                         PAL07010
   15 DO 25 J=1.2
                                                                         PAL07020
          DO 20 I=1.8
                                                                         PAL07030
   20
              IIN (I, J) = IBLANK
                                                                         PAL07040
   25 CONTINUE
                                                                         PAL07050
      IIN(2,1) = IPAL(1)
                                                                         PAL07060
      IIN (4, 1) = IPAL (2)
                                                                         PAL07070
      IIN(ó, 1) = IPAL(3)
                                                                         PAL07080
      IIN(1,2) = INAME(1)
                                                                         PAL07090
                                                                         PALO 7100
      IIN(3,2) = INAME(2)
                                                                         PAL07110
      IIN (5,2) = INAME (3)
                                                                         PAL07120
      IIN(7,2) = INAME(4)
      IIN(8,2) = INAME(5)
                                                                         PALO7130
      J = 0
                                                                         PAL07140
      I L = 0
                                                                         PALO7150
```

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FILE: PAL24
                 FORTRAN
                               NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
   30 IC=0
                                                                                  PAL07160
      IL=IL+1
                                                                                  PAL07170
   35 IC=IC+1
                                                                                  PAL07180
   40 IF ( IC.GT.80 ) GO TO 30
                                                                                  PAL07190
      IF ( IPAGE (IC, IL), EQ, IBLANK ) GO TO 35
                                                                                  PAL07200
      J=J+1
                                                                                  PAL07210
      IF (J.GT. 24) GO TO 60
                                                                                  PAL07220
      DO 55 I=1,12
                                                                                  PAL07230
           PIN(I,J) = IPAGE(IC,IL)
                                                                                  PAL07240
           IC=IC+1
                                                                                  PAL07250
           IF( IC.GT.80 ) GO TO 40
                                                                                  PAL07260
                                                                                  PAL07270
           IF ( IPAGE (IC, IL), EQ, IBLANK ) GO TO 40
   55
           CONTINUE
                                                                                  PAL07280
   60 DO 75 J=1,12
                                                                                  PAL07290
           II=0
                                                                                  PAL07300
   65
           II=II+1
                                                                                  PAL07310
           IF (II.EQ. 13) GO TO 75
                                                                                  PAL07320
           IF ( PIN(II, J) . NE. IBLANK ) GO TO 65
                                                                                  PALO7330
           T = 13
                                                                                  PAL07340
   70
           I = I - 1
                                                                                  PAL07350
           II=II-1
                                                                                  PAL07360
           PIN(I,J) = PIN(II,J)
                                                                                  PAL07370
           PIN(II, J) = IBLANK
                                                                                  PAL07380
           IF (II.NE. 1) GO TO 70
                                                                                  PAL07390
   75 CONTINUE
                                                                                  PAL07400
      WRITE (POF, 76) TITLE
                                                                                  PAL07410
   76 FORMAT (/, 1 , 80A1)
                                                                                  PAL07420
      WRITE (POF, 78) ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                                                                                  PAL07430
                      ISTAR, ISTAH, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                                                                                  PAL07440
                      ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                                                                                  PAL07450
                      ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR
                                                                                  PAL07460
   78 FORMAT (/, 1 1, 18x, 14A1, 3x, 14A1,
                                                                                  PALO7470
                  ', 18X, A1, 13X, A1, 1X, A1, 13X, A1)
                                                                                  PAL07480
      JJ = 24
                                                                                  PAL07490
      DO 88 J=1,12
                                                                                  PAL07500
           WRITE (POF, 80) ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR PALO7510
   80
           FORMAT (' ', 15x, 4A1, 29x, 4A1)
                                                                                  PAL07520
           WRITE (POF, 81) (PIN (I,J), I=1, 12), ISTAR, J, ISTAR,
                                                                                  PALO 7530
                 (IIN(I, 1), I=1, 8), ISTAR, JJ, ISTAR, (PIN(I, JJ), I=1, 12)
                                                                                  PAL07540
   81
           FORMAT (' ', 12A1, 3X, A1, 12, A1, 11X, 8A1, 10X, A1, 12, A1, 3X, 12A1)
                                                                                  PAL07550
           WRITE (POF, 82) ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR PALO7560
   82
           FORMAT ( ' ', 15x, 4x1, 29x, 4x1)
                                                                                  PAL07570
           WRITE (POF, 84) ISTAR, (IIN (1,2), 1=1,8), ISTAR
                                                                                  PAL07580
   84
           FORMAT (* ', 18x, A1, 11x, 8A1, 10x, A1)
                                                                                  PAL07590
           DO 86 II=1,2
                                                                                  PAL07600
               DO 85 1=1,8
                                                                                  PAL07610
   85
                    IIN (I, II) = IBLANK
                                                                                  PAL07620
           CONTINUE
   86
                                                                                  PAL07630
           JJ=JJ-1
                                                                                  PAL07640
  .88 CONTINUE
                                                                                  PAL07650
      WRITE (POF, 90) ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                                                                                  PAL07660
     1
                      ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                                                                                  PAL07670
     2
                                                                                  PAL07680
                      ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR,
                      ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR, ISTAR
                                                                                  PAL07690
   90 FURMAT(' ', 18X, 31A1)
                                                                                  PAL07700
```

FILE: PAL24 FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0

```
PAL07710
      RETURN
      END
                                                                            PAL07720
                                                                            PAL07730
C
C
                                                                            PAL07750
      SUBROUTINE PLOT (LBUF, IBUF, LFUSES, IPROD, TITLE, LDUMP, ITYPE, LPROD,
                                                                            PALO7760
                       IOP, IBLOW)
                                                                            PAL07770
C
      THIS SUBROUTINE PRODUCES THE FUSE PLOT
                                                                            PAL07780
                                                                            PAL07790
      IMPLICIT INTEGER (A-Z)
      INTEGER IBUF (8,24), IOUT (64), ISAVE (80,40), TITLE (80), IDATA (40)
                                                                            PAL07800
                                                                            PAL07810
      LOGICAL LBUF (24), LFUSES (40,80), LDUMP, LPROD (80)
                                                                            PAL07820
      INTEGER
                STX.ETX
      COMMON /LUNIT/ PMS, POF, PDF
                                                                            PAL07830
      DATA ISAVE/3200*' '/, IAND/'*'/, IOR/'+'/, ISLASH/'/'/,
                                                                            PAL07840
     1
           IDASH/'-'/, X/'X'/, IBLANK/' '/, P/'P'/, B/'B'/,
                                                                            PAL07850
           D/'D'/, ZERO/'O'/, ONE/'1'/, FX/'O'/, FIDASH/'O'/
                                                                            PAL07860
      DATA STX/Z02000000/, ETX/Z03000000/
                                                                            PAL07870
      IF (LOUMP) GO TO 58
                                                                            PALO7880
                                                                            PAL07890
      IF (ISAVE (IPROD, 1) . NE. IBLANK) RETURN
      IF (LBUF (1)) GO TO 5
                                                                            PAL07900
      DO 30 J=1,39
                                                                           PAL07910
          ISAVE (IPROD. J) = LSAVE (IPROD. J+1)
                                                                           PAL07920
      ISAVE (IPROD, 40) = ISLASH
                                                                            PAL07930
    5 DO 20 I=1,8
                                                                            PAL07940
         IF ( ISAVE (IPROD. 1) . NE. IBLANK ) RETURN
                                                                            PAL07950
                                                                            PAL07960
          IF ( IBUF (I, 1) . EQ. IBLANK ) GO TO 26
                                                                           PAL07970
          DO 10 J=1,39
   10
              ISAVE (IPROD, J) = ISAVE (IPROD, J+1)
                                                                           PAL07980
                                                                            PAL07990
          ISAVE (IPROD, 40) = IBUF (1, 1)
                                                                            PAL08000
   20
          CONTINUE
      IF (ISAVE (IPROD, 1) . NE. IBLANK) RETURN
                                                                            PAL08010
   40 DO 50 J=1,39
                                                                            PAL08020
   50
          ISAVE (IPROD, J) = ISAVE (IPROD, J+1)
                                                                            PAL08030
      ISAVE (IPROD, 40) = IAND
                                                                            PAL08040
      RETURN
                                                                            PAL08050
                                                                            PAL08060
      PRINT FUSE PLOT
                                                                            PAL08070
   58 IF (IOP.E.D) GO TO 62
      WRITE (POF, 61) TITLE
                                                                            PAL08080
   61 FORMAT (/, 1 1,80A1,//,
                                                                            PALOS090
     1 .
                         11 1111 1111 2222 2222 2233 3333 3333',/,
                                                                            PAL08100
                                                                          PAL08110
     2 •
            0123 4567 8901 2345 6789 0123 4567 8901 2345 67891,/)
      GO TO 64
                                                                            PAL08120
C**** STX DETERMINES THE STARTING CHARACTER FOR DATA I/O FORMAT
                                                                            PAL08130
                                                                            PAL08 140
   62 WRITE (PDF, 63) STX
   63 FORMAT (' ', A1, '*L0000'/)
                                                                            PAL08150
                                                                            PAL08160
   64 DO 100 188PRO=1,73,8
          DO 94 I8PRO=1.8
                                                                            PAL08170
                                                                            PAL08180
              IPROD=188PRO+18PRO-1
              ISAVE (IPROD, 40) = IBLANK
                                                                            PAL08190
              DO 70 I=1.40
                                                                            PAL08200
                                                                            PAL08210
                  IF ( ISAVE (IPROD. 1), NE, IBLANK ) GO TO 70
                   DO 65 J=1,39
                                                                           PAL08220
   65
                       ISAVE (IPROD, J) = ISAVE (IPROD, J+1)
                                                                            PAL08230
                  ISAVE (IPROD, 40) = IELAKK
                                                                           PAL08240
   70
                  CONTINUE
                                                                            PAL08250
```

```
FILE: PAL24
                FORIRAN
                              NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
               DO 75 I=1.24
                                                                               PAL08260
                    IOUT (I+40) = ISAVE (IPROD, I)
                                                                               PAL08270
   75
                                                                               PAL08280
               IF ( ISAVE (IPROD, 25), NE, IBLANK ) IOUT (64) = IDASH
                                                                               PAL08290
               DO 80 1=1,40
                                                                               PAL08300
                   IOUT (I) =X
                                                                               PAL08310
                    IF (LFUSES (I, IPROD)) IOUT (I) = IDASH
                                                                               PAL08320
   80
               CONTINUE
                                                                               PAL08330
               CALL FANTOM (ITYPE, IOP, IOUT, IPROD, I8PRO)
                                                                               PAL08340
               IF (IOP.NE.D) GO TO 85
                                                                               PAL08350
               K = 0
                                                                               PAL08360
   8 1
               DO 82 I=1.40
                                                                               PAL08370
                  IF ((IOUT(I), EQ.FX), OR. (IOUT(I), EQ.FIDASH)) GO TO 82
                                                                               PAL08380
                                                                               PAL08390
                  K = K + 1
                  IF (IOUT (I) . EQ. X)
                                         IDATA (K) = ZERO
                                                                               PAL08400
                  IF (IOUT (I) . EQ. IDASH) IDATA (K) = ONE
                                                                               PAL08410
   82
               CONTINUE
                                                                               PAL08420
               DO 83 I=1,40
                                                                               PALOSURO
                  IF ( (IOUT(I) .EQ.X) .OR. (IOUT(I) .EQ.IDASH) ) GO TO 86
                                                                               PAL08440
   83
               CONTINUE
                                                                               PAL 08450
               GO TO 94
                                                                               PAL08460
   86
               WRITE (PDF, 34) IDATA
                                                                               PAL08470
   84
               FORMAT ( ', 40 (A1, '))
                                                                               PAL08480
               30 TO 94
                                                                               PAL08490
   85
               IPROD=IPROD-1
                                                                               PAL08500
               IF ( (IOP, EQ.P), OR, (IOP, EQ.B.AND, (LPROD (IPROD+1))) )
                                                                               PAL08510
     1
               WRITE (POF, 90) IPROD, IOUT
                                                                               PAL08520
   90
               FURNAT (' ', 12, 10 (' ', 4 A 1) , ' ', 2 4 A 1)
                                                                               PAL08530
   94
               CONTINUE
                                                                               PAL08540
           WRITE (POF, 96)
                                                                               PAL08550
   96
           FORMAT (1X)
                                                                               PAL08560
  100
          CONTINUE
                                                                               PAL08570
      IF (IOP, NZ, D) GO TO 105
                                                                               PAL08580
      WRITE (PDF, 101) ETX
                                                                               PAL08590
  101 FORMAT ( ' ', A 1)
                                                                               PAL08600
      RETURN
                                                                               PAL08610
  105 WRITE (POF, 110)
                                                                               PAL08620
  110 FORMAT (/,
                                                                               PAL08630
                  X : FUSE NOT BLOWN (L,N,U) - : FUSE BLOWN
                                                                     (H,P,1) ) PAL08640
     I' LEGEND:
      IF (IOP.EQ.P) WRITE (POF, 111)
                                                                               PAL08650
  111 FORMAT (
                                                                               PAL08660
     11
                  0 : PHANTOM FUSE
                                       (L, N, 0) O: PHANTON FUSE (H, P, 1) ') PAL 08670
      WRITE (POF, 112) IBLOW
                                                                               PAL08680
  112 FORMAT (/, NUMBER OF FUSES BLOW = 1,14)
                                                                               PAL08690
      WRITE (POF, 113)
                                                                               PAL 08700
  113 FORMAT (//)
                                                                               PAL08710
      RETURN
                                                                               PAL08720
      END
                                                                               PAL08730
C
                                                                               PAL08740
*****PAL08750
                                                                               PAL08760
      SUBROUTINE HEX (LFUSES, IOF)
                                                                               PAL08770
C
      THIS SUBROUTINE GENERATES HEX PROGRAMMING FORMATS
                                                                               PAL08780
      IMPLICIT INTEGER (A-Z)
                                                                               PAL08790
      INTEGER ITEMP (80), ZTABL1 (32), ZTABL2 (16), ZCSUM (4)
                                                                               PAL08800
```

```
NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
FILE: PAL24
                FORTRAN A
                                                                               PAL08810
      LOGICAL LFUSES (40,80)
      INTEGER SOH, STX, ETA, BEL
                                                                               PAL08820
                                                                               PAL08830
      COMMON /LUNIT/PMS, POF, PDF
      DATA H/'H'/,S/'S'/,IBLANK/' '/,
ZTABL1/'00','01','02','03','04','05','06','07',
                                                                               PAL08840
                                                                               PALOB850
                    1081,1091,10A1,10B1,10C1,10D1,10E1,10F1,
                                                                               PAL08860
     2
                    1101, 1111, 1121, 1131, 1141, 1151, 1161, 1171,
                                                                               PAL08870
     3
     4
                    '18','19','1A','1B','1C','1D','1E','1F'/,
                                                                               DALO8880
            ZTABL2/101, 111, 121, 131, 141, 151, 161, 171,
                                                                               PAL08890
     5
                    181, 191, 1A1, 1B1, 1C1, 1D1, 1E1, 1F1/
                                                                               PAL08900
      DATA SOH/Z01000000/,STX/Z0200000/,
                                                                               PAL08910
                                                                               PAL03920
          ETX/203000000/.BEL/20700000/
      CSUM=0
                                                                               PALD8930
                                                                               PAL08940
      IF (IOP, EQ. H) WRITE (PDF, 10)
   10 FORMAT (//,80 (' '),//)
                                                                               PAL08950
C**** NOTE: SOME PROM PROGRAMMERS NEED A START CHARACTER.
                                                                               PAL08960
C * * * * *
              THIS PROGRAM OUTPUTS AN STX FOR THE DATA I/O MODEL 9
                                                                               PAL08970
                (USE SOH FOR MODEL 5)
C * * * * *
                                                                               O868018d
      WRITE (PDF, 5) BEL, BEL, BEL, BEL, BEL, BEL, STX, SOH
                                                                               PAL08990
    5 FORMAT (1 1,9A1)
                                                                               PAL09000
                                                                               PAL09010
      DO 40 I=1,41,40
                                                                               PAL09020
      INC=I-1
                                                                               PAL09030
         DO 40 IPROD=1,7,2
          DO 20 J=1,2
                                                                               PAL09040
                                                                               PAL09050
               DO 20 IINFUT=1.40
                                                                               PAL09060
               IHEX=0
                                                                               PAL09070
               ISUM 2 = IPROD + J - 1 + INC
               IF (LFUSES (IINPUT, ISUM2 + 0 )) IHEX=IHEX+1
                                                                               PAL09080
               IF (LFUSES (IINPUT, ISUM2 + 8 )) IHEX=IHEX+2
                                                                               PAL09090
               IF (LFUSES (IINPUT, ISUM2 + 16 )) IHEX=IHEX+4
                                                                               PALC9 100
               IF (LFUSES (IINPUT, ISUM2 + 24 )) IHEX=IHEX+8
                                                                               PAL09110
               IF (LFUSES (IINPUT, ISUM2 + 32 )) IHEX=IHEX+16
                                                                               PAL09120
                                                                               PAL 09 130
               CSUM=CSUM+IHEX
                                                                               PAL09140
               ISUMX = IINPUT + (40 + (J-1))
                                                                               PAL09150
   20
               ITEMP (ISUNX) = 2TABL1 (THEX+1)
                                                                               PAL09160
           IF (IOP. EQ. h) WRITE (PDF, 60) ITEMP
   60
           FORMAT (4 (' ', 20 (A2, ' '), '.',/))
                                                                               PAL09170
   40
           IF (IOP.EQ.S) WRITE (PDF, 61) ITEMP
                                                                               PAL09 180
           FORMAT (4 (* 1,20A2,1,1,/))
                                                                               PAL09190
   61
      IF (IOP.EQ.H) WRITE (PDF, 70)
                                                                               PAL09200
                                                                               PAL09210
   70 FORMAT (//, 80 (' '),//)
                                                                               PAL09220
      WRITE (PDF, 80) ETX
   80 FORMAT (' ', A 1)
                                                                               PAL09230
                                                                               PAL09240
C
      CONVERT DECIMAL CHECK SUM INTO HEX CHECK SUM
                                                                               PAL09250
      DO 85 I=1,4
                                                                               PAL09260
            ZTEMP=CSUM-16* (CSUM/16)
                                                                               PAL09270
            ZCSUM (5-I) =ZTABL2 (ZTEMP+1)
                                                                               PAL09280
            CSUM=CSUM/16
                                                                               PAL09290
   85 CONTINUE
                                                                               PAL09300
      IF(ZCSUM(1).EQ.ZTABL2(1)) ZCSUM(1)=IBLANK
      WRITE(PMS, 90) ZCSUM(1), ZCSUM(2), ZCSUM(3), ZCSUM(4)
                                                                               PAL09310
   90 FORMAT (/, ' HEX CHECK SUM = ',4A1)
                                                                               PAL09320
                                                                               PAL09330
      RETURN
                                                                               PAL09340
      END
```

С

```
FILE: PAL24
               FORTRAN A
                            NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
PAL09370
      BLOCK DATA
                                                                        PAL09380
      IMPLICIT INTEGER (A-2)
                                                                        PAL09390
      COMMON /BLK/ PR8X10(10,14), PROD8(8,11), PRODLN(40,7)
                                                                        PAL09400
      DATA PREXIO/
                                                                        PAL09410
            4, 4, 4, 4, 4, 4, 4, 4, 4,
                                                                        PAL09420
                  5, 5, 5, 5, 5, 5,
     2
            3, 6,
                                    6,
                                                                        PAL09430
     3
            3, 3, 7,
                     7, 8, 8, 7, 7,
                                    3,
                                                                        PAL09440
     4
                     9,10,10, 9, 3,
                                                                        PAL09450
            3.
               3, 3,
                                    3,
     5
            3, 3,
                                    3, 3,
                  3,
                     3, 1, 1,
                              3, 3,
                                                                        PAL09460
     6
            2, 2, 2, 2, 1, 1, 3, 3, 3, 3,
                                                                        PAL09470
     7
           PAL09480
     8
           PAL09490
     9
           11,11,11,11,11,11,11,11,11,11,11,
                                                                        PAL09500
     Α
           PAL09510
     В
            3, 1, 1, 1, 1, 1, 1, 1, 1, 3,
                                                                        PAL09520
     С
            3, 1, 1, 1, 1, 1, 1, 1, 3,
                                                                        PAL09530
            3, 1, 1, 1, 1, 1, 1, 1, 1, 3,
     D
                                                                        PAL09540
            3, 1, 1, 1, 1, 1, 1, 1, 1, 3/
     Ε
                                                                        PAL09550
     DATA PRODE/
                                                                        PAL09560
           1, 1, 1, 1, 1, 1, 1, 1, 1,
     1
                                                                        PAL09570
     2
           2,2,2,2,2,2,2,2,
                                                                        PAL09580
     3
           3,3,3,3,3,3,3,3,
                                                                        PAL09590
           4,4,3,3,3,3,3,3,3,
                                                                        PAL09600
     5
           5,5,3,3,3,3,3,3,
                                                                        PAL09610
           5,5,5,5,3,3,3,3,
                                                                        PAL09620
     7
           6,6,6,6,3,3,3,3,3,
                                                                        PAL09630
     8
           6,6,3,3,3,3,3,3,3,
                                                                        PAL09640
     9
           7,7,7,7,7,7,3,3,
                                                                        PAL03650
     À
           7,7,7,7,3,3,3,3,3,
                                                                        PAL09660
     В
           1, 1, 1, 1, 3, 3, 3, 3/
                                                                        PAL09670
     DATA PRODLNY
                                                                        PAL09680
     ١
           40¢lax.
                                                                        PAL09690
     2
           40 + 1HP,
                                                                        PAL09700
     3
           40*1HN,
                                                                        PAL0971G
     u
           6 * 1 H X , 2 * 1 d P , 2 * 1 H X , 2 * 1 H P , 2 * 1 H X , 2 * 1 H P , 2 * 1 H X ,
                                                                        PAL09723
     4
           2*1HP,2*1HX,2*1HP,2*1HX,2*1HP,2*1HX,2*1HP,
                                                                        PAL09730
     4
           2*1HX,2*1HP,4*1HX,
                                                                        PAL09740
     5
           10 + 1HX, 2 + 1HP, 2 + 1HX, 2 + 1HP, 2 + 1HX, 2 + 1HP, 2 + 1HX,
                                                                        PAL09750
     5
           2 * 1HP, 2 * 1HX, 2 * 1HP, 2 * 1HX, 2 * 1HP, 8 * 1HX,
                                                                        PAL09760
     6
           14 + 1 H x , 2 + 1 H P , 2 + 1 H x , 2 + 1 H P , 2 + 1 H X , 2 + 1 H P , 2 + 1 H X ,
                                                                        PAL09770
     6
           2*1HP, 12*1HX,
                                                                        PAL09780
           18 * 1HX, 2 * 1HP, 2 * 1HX, 2 * 1HP, 16 * 1HX/
                                                                        PAL09790
      END
                                                                        PAL09800
                                                                        PAL09810
PAL09830
C
      SUBROUTINE TWEEK (ITYPE, LFUSES)
                                                                        PAL09840
C
      THIS SUBROUTINE THEEKS LEUSES (THE PROGRAMMING FUSE PLOT)
                                                                        PAL09850
С
       FOR HIGH AND LOW PHANTOM FUSES
                                                                        PAL09860
      IMPLICIT INTEGER (A-Z)
                                                                        PAL09870
      LOGICAL LFUSES (40,80), LBLANK, LLEFT, LAND, LOR, LSLASH,
                                                                        PAL09880
              LEQUAL, LRIGHT, LXOR
                                                                        PAL09890
```

COMMON LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR

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FILE: PAL24
               FORTRAN
                             NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      COMMON /BLK/ PR8X10(10,14), PROD8(8,11), PRODLN(40,7)
                                                                          PAL09910
      DATA P/'P'/, N/'N'/
                                                                          PAL09920
      FUSPTR= 1
                                                                          PAL09930
      DO 30 OUTPUT=1,10
                                                                          PAL09940
         GRTYPE=PR3X10 (OUTPUT, ITYPE)
                                                                          PAL09950
         DO 30 PRLINE=1,8
                                                                          PAL09960
            LNTYPE=PRODS (PRLINE, GRTYPE)
                                                                          PAL09970
            DO 20 COL=1,40
                                                                          PAL09980
               IF (PRODLM (COL, LNTYPE) . EQ. P)
                                                                          PAL09990
                  LFUSES (COL, FUSPTR) = . TRUE.
                                                                          PAL 10000
               IF (PRODLN (COL, LNTYPE) . EQ. N)
                                                                          PAL 10010
                  LFUSES (COL, FUSPTR) = FALSE.
                                                                          PAL 10020
   20
            CONTINUE
                                                                          PAL10030
            FUSPTR=FUSPTR+1
                                                                          PAL 10040
   30 CONTINUE
                                                                          PAL 10050
      RETURN
                                                                          PAL 10060
      END
                                                                          PAL10070
С
                                                                          PAL 10080
С
                                                                          PAL 10 100
      SUBROUTINE BINR (LFUSES, H. L)
                                                                          PAL 10 110
c
      THIS SUBROUTINE GENERATES BINARY PROGRAMMING FORMATS
                                                                          PAL 10 120
      IMPLICIT INTEGER (A-Z)
                                                                          PAL10130
      INTEGER ITEMP (5, 10)
                                                                          PAL 10 140
      LOGICAL LFUSES (40,80)
                                                                          PAL 10150
      COMMON /LUNIT/ PMS. POF. PDF
                                                                          PAL10160
      WRITE (PDF, 10)
                                                                          PAL10170
   10 FORMAT (//, '
                                                            .1.//)
                                                                          PAL10180
      DO 20 I=1,41,40
                                                                          PAL 10 190
      INC=I-1
                                                                          PAL10200
        DO 20 IPROD=1.8
                                                                          PAL 10210
            DO 20 J=1,31,10
                                                                          PAL 10220
              DO 15 K=1.10
                                                                          PAL 10230
                IINPUT=J+K-1
                                                                          PAL 10240
                                                                          PAL 10250
                ITEMP (1,K) = L
                ITEMP (2,K)=L
                                                                          PAL 10260
                ITEMP (3,K) = L
                                                                          PAL 10270
                ITEMP (4,K) = L
                                                                          PAL 10280
                ITEMP (5,K) = L
                                                                          PAL 10290
                ISUM3=IPROD+INC
                                                                          PAL 10300
                IF (LFUSES (IINPUT, ISUM3 + 0)) ITEMP (5, K) = H
                                                                          PAL 10310
                IF (LFUSES (IINPUT, ISUN3 + 8 )) ITEMP (4, K) = H
                                                                          PAL 10320
                IF (LFUSES (IINPUT, ISUN3 + 16 )) ITEMP (3, K) = H
                                                                          PAL 10330
                                                                          PAL 10340
                IF (LFUSES (IINPUT, ISUN3 + 24 )) ITEMP (2, K) = H
                IF (LFUSES (IINPUT, ISUM3 + 32 )) ITEMP (1, K) = H
                                                                         PAL 10350
   15
                CONTINUE
                                                                          PAL 10360
   20
                                                                          PAL 10370
              WRITE (PDF, 30) ITEMP
   30
              FORMAT ('. ', 10 ('B', 5A1, 'F '))
                                                                          PAL 10380
      WRITE (PDF, 10)
                                                                          PAL 10 390
      RETURN .
                                                                          PAL 10400
      END
                                                                          PAL 104 10
c
                                                                          PAL 10420
PAL 10440
      SUBROUTINE SLIP (LFUSES, 188PRO, ITYPE, IBLOW)
                                                                          PAL10450
```

```
FILE: PAL24
                FORTRAN
                               NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
C
      THIS SUBROUTINE WILL BLOW THE ENTIRE CONDITIONAL THREE-STATE
                                                                               PAL 10460
       PRODUCT LINE WHEN 'IF (VCC)' CONDITION IS USED FOR THE
                                                                               PAL 10470
       CORRESPONDING OUTPUT PIN
                                                                               PAL10480
      IMPLICIT INTEGER (A-Z)
                                                                               PAL 10490
      INTEGER LENABL (10, 14)
                                                                               PAL 10500
      LOGICAL LFUSES (40,80)
                                                                               PAL 10510
c
      1=ENABLED OUTPUT.
                            D=ANYTHING ELSE FOR THAT OUTPUT
                                                                               PAL 10520
      DATA IENABL/
                                                                               PAL10530
            0,0,0,0,0,0,0,0,0,0,0,
                                                                               PAL 10540
            0,0,0,0,0,0,0,0,0,0,0,
                                                                               PAL 10550
            0,0,0,0,0,0,0,0,0,0,0,
                                                                               PAL 10560
     Ų
            0,0,0,0,0,0,0,0,0,0,0,
                                                                               PAL 10570
     5
            0,0,0,0,0,0,0,0,0,0,0,
                                                                               PAL 10580
            0,0,0,0,0,0,0,0,0,0,
                                                                               PAL 10590
     7
            1, 1, 1, 1, 1, 1, 1, 1, 1, 1,
                                                                              PAL 10600
            0,0,0,0,0,0,0,0,0,0,0,
     8
                                                                               PAL 10610
     9
            1,0,0,0,0,0,0,0,0,1,
                                                                               PAL 10620
            1,1,1,0,0,0,0,1,1,1,1,
                                                                               PAL 10630
     В
            0,1,1,1,1,1,1,1,1,0,
                                                                               PAL 10640
     С
            0,0,0,0,0,0,0,0,0,0,0
                                                                               PAL 10650
     D
            0,1,0,0,0,0,0,0,1,0,
                                                                               PAL 10660
            0,1,1,0,0,0,0,1,1,0/
                                                                               PAL 10670
      IOUT = (188PRO-1)/8+1
                                                                               PAL 10680
      IF (IENABL (IOUT, ITYPE) . EQ.O) RETURN
                                                                               PAL 10690
      DO 10 I=1.40
                                                                               PAL 10700
      IBLOW = IBLOW + 1
                                                                               PAL 10710
   10 LFUSES(I, 188PRO) = .TRUE.
                                                                               PAL 10720
      I88PRO = I88PRO + 1
                                                                               PAL10730
      RETURN
                                                                               PAL 10740
      END
                                                                               PAL 10750
c
                                                                               PAL 10760
C***********
                                                                          *****PAL 10770
С
                                                                               PAL 10780
      SUBROUTINE FANTON (ITYPE, IOP, IOUT, IPROD, 18PRO)
                                                                               PAL 10790
c
      THIS SUBADULINE UPDATES IOUT (THE PRINTED PUSE PLOT)
                                                                               PAL 10800
c
       FOR HIGH AND LOW PHANTOM FUSES
                                                                               PAL 10810
      INPLICIT INTEGER (A-Z)
                                                                               PAL 10820
      INTEGER TOUT (64)
                                                                               PAL10830
      LOGICAL LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR
                                                                               PAL 10840
      COMMON LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR
                                                                               PAL 10850
      COMMON /BLK/ PR8X10(10,14), PROD8(8,11), PRODLN(40,7)
                                                                               PAL 10860
      DATA B/'B'/, N/'N'/, P/'P'/, LOFANT/'O'/, HIFANT/'O'/, IBLANK/' '/
                                                                               PAL 10870
С
      GET OUTPUT GROUPING
                                                                               PAL 10880
      OUTPUT= (IPROD-1) /8+1
                                                                               PAL 10890
      GRTYPE=PRBX 10 (OUTPUT, ITYPE)
                                                                               PAL 10900
      LNTYPE=PRODS (ISPRO, GRTYPE)
                                                                               PAL 10910
      DO 10 COL=1,40
                                                                               PAL 10920
          IF ( PRODLN (COL, LNTYPE) . EQ. P. AND. IOP. EQ. P ) IOUT (COL) =HIFANT
                                                                               PAL 10930
          IF ( PRODLN (COL, LNTYPE) . EQ. P. AND. IOP. EQ. B ) IOUT (COL) = IBLANK
                                                                               PAL 10940
          IF ( PRODLN (COL, LNTYPE), EQ.N )
                                                         IOUT (COL) = LOFANT
                                                                               PAL 10950
   10 CONTINUE
                                                                               PAL 10960
      RETURN
                                                                               PAL 10970
      END
                                                                               PAL 10980
C
                                                                               PAL 10990
                                                                         *****PAL 11000
```

```
FILE: PAL24
               FORTRAN
                             NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
C
                                                                          PAL11010
      SUBROUTINE IODC2
                                                                          PAL 11020
C**** THIS ROUTINE IS OPTIONAL, IT MAY BE USED TO TURN PERIPHERALS ON
                                                                          PAL 11030
      IMPLICIT INTEGER (A-Z)
                                                                          PAL 11040
      INTEGER
                BEL, DC2
                                                                          PAL 11050
      COMMON /LUNIT/ PMS.POF.PDF
                                                                          PAL 11060
      DATA BEL/207000000/, DC2/222000000/
                                                                          PAL 11070
      WRITE (PDF, 10) DC2, BEL
                                                                          PAL 11080
   10 FORMAT ( 1, 2A1)
                                                                          PAL 11090
      RETURN
                                                                          C01111A4
      END
                                                                          PAL 11110
С
                                                                          PAL 11120
C
                                                                          PAL 11140
      SUBROUTINE IODC4
                                                                          PAL 11150
C***** THIS ROUPINE IS OPTIONAL, IT MAY BE USED TO TURN PERIPHERALS OFF PALITIES
      IMPLICIT INTEGER (A-Z)
                                                                          PAL11170
                BEL, DC3, DC4
      INTEGER
                                                                          PAL 11180
      DATA BEL/207000000/, DC3/223000000/, DC4/224000000/
                                                                          PAL 11190
      WRITE (PDF, 10) BEL, DC3, DC4
                                                                          PAL 11200
   10 FORMAT(' ', 3A1)
                                                                          PAL 11210
      RETURN
                                                                          PAL 11220
      END
                                                                          PAL 11230
                                                                          PAL 11240
C
                                                                          PAL 11260
      SUBROUTINE TEST (LPHASE, LBUF, TITLE, IC, IL, ILE, ISYM, IBUF, ITYPE,
                                                                          PAL 11270
                      IPCTR, LERR, ISAF, IPCTR 1, LSA 11, LSA 01)
                                                                          PAL11280
C
      THIS SUBROUTINE PERFORMS THE FUNCTION TABLE SIMULATION
                                                                          PAL11290
C
       AND GENERATES TEST VECTORS
                                                                          PAL 11300
      IMPLICIT INTEGER (A-Z)
                                                                          PAL 11310
      INTEGER ISYM (8,24), ISYM 1 (8,24), IBUF (8,24), IVECT (24), IVECTP (24),
                                                                          PAL 11320
              ISTATE (24), ISTATT (24), IPIN (24), TITLE (80), IPCTR
                                                                          PAL 11330
      LOGICAL LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR, LSAME,
                                                                          PAL 11340
     1
              XORFND, LERR, LPHASE (24), LPHAS1 (24), LBUF (24), LOUT (24),
                                                                          PAL 11350
              LOUTP (24), LCLOCK, LPTRST, LCTRST, LENABL (24), NREG,
     2
                                                                          PAL 11360
              LSA11, LSA12, LSA01, LSA02.
                                                                          PAL 11370
     3
      INTEGER
                BEL
                                                                          PAL 11380
      COMMON LBLANK, LLEFT, LAND, LOR, LSLASH, LEQUAL, LRIGHT, LXOR
                                                                          PAL 11390
                                                                          PAL 11400
      COMMON /PGE/ IPAGE (80, 200)
      COMMON /LUNIT/ PMS, POF, PDF
                                                                          PAL11410
      COMMON /FTEST/ IFUNCT, IDESC, IEND
                                                                          PAL 11420
      DATA IDASH/'-'/, L/'L'/, H/'H'/, X/'X'/, C/'C'/, Z/'Z'/, NO/'O'/,
                                                                          PAL11430
           N1/'1'/, ERR/'?'/, IBLANK/' '/, COMENT/';'/
                                                                          PAL 11440
      DATA BEL/20700000/
                                                                          PAL 11450
c
      PRINT AN ERROR MESSAGE IF NO FUNCTION TABLE IS SUPPLIED
                                                                          PAL 11460
      IF (IFUNCT, NE, 0) GO TO 3
                                                                          PAL 11470
      WRITE (PMS, 2)
                                                                          PAL 11480
   2 FORMAT (/, FUNCTION TABLE MUST BE SUPPLIED IN ORDER TO PERFORM'.
                                                                          PAL 11490
               ' SIMULATION')
                                                                          PAL 11500
                                                                          PAL 11510
      RETURN
C
                                                                          PAL 11520
      PRINT TITLE
    3 IF ((.NOT.LSA11).AND.(.NOT.LSA01)) WRITE (POF,4) TITLE
                                                                          PAL 11530
    4 FORMAT (/,' ',80A1,/)
                                                                          PAL 11540
```

INITIALIZE LERR (FUNCTION TABLE ERROR FLAG) TO NO ERROR

```
FILE: PAL24
                FORTRAN A
                               NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
      LERR= , FALSE .
                                                                                PAL 11560
С
      INITIALIZE NERR (NUMBER OF FUNCTION TABLE ERRORS) TO NO ERROR
                                                                                PAL 11570
      NERR=0
                                                                                PAL 11580
C
      SET THE STARTING POINT OF THE FUNCTION TABLE TO COLUMN O
                                                                                PAL 11590
С
       AND IFUNCT + 1.
                                                                                PAL 11600
      IC=0
                                                                                PAL 11610
      IL=IFUNCT + 1
                                                                                PAL 11620
C
      INITIALISE SA1/SAO PARAMETERS
                                                                                PAL 11630
      IPCTR3=0
                                                                                PAL 11640
      IEQN=0
                                                                                PAL 11650
      IPCTR=0
                                                                                PAL 11660
      INITIALIZE ITRST (THREE-STATE ENABLE FUNCTION TABLE PIN NUMBER)
c
                                                                                PAL 11670
      ITRST=J
                                                                                PAL11680
C
      MAKE A DUMMY CALL TO INCR
                                                                                PAL11690
      CALL INCR(IC, IL)
                                                                                PAL 11700
C
      GET THE FUNCTION TABLE PIN LIST (UP TO 22)
                                                                                PAL 11710
c
       GO ONE MORE THAN MAX TO LOOK FOR DASHED LINE
                                                                                PAL 11720
                                                                                PAL 11730
      DO 10 I=1.23
      CALL GETSYM (LPHAS1, ISYM1, I, IC, IL)
                                                                                PAL 11740
          DO 5 J=1.8
                                                                                PAL 11750
          IBUF(J, 1) = ISYMI(J, I)
                                                                                PAL 11760
      IF (IBUF (8, 1), EQ. IDASH) GO TO 12
                                                                                PAL11770
      CALL MATCH (IMATCH, IBUF, ISYM)
                                                                                PAL 11780
     IF (IMATCH, NE.O) GO TO 7
                                                                                PAL 11790
      WRITE (PMS, 6) (IBUF (J, 1), J=1.8)
                                                                                PAL 11800
    6 FORMAT (/, FUNCTION TABLE PIN LIST ERROR AT', 8A1)
                                                                                PAL 11810
      RETURN
                                                                                PAL 11820
    7 LOUT (I) = . FALSE.
                                                                                PAL11830
                                                                                PAL11840
      ISTATT(I) = X
      IVECTP(I) = X
                                                                                PAL11850
С
      IF APPROPIATE PAL TYPE, REMEMBER LOCATION OF CLOCK AND THREE-STATEPAL 11860
       ENABLE PIN IN FUNCTION TABLE PIN LIST
C
                                                                                PAL 11870
      IF ( .NOT. (ITYPE, EQ. 8. OR. ITYPE, EQ. 9. OB. ITYPE, EQ. 10. OR. .
                                                                                PAL 11880
                 ITYPE.EQ. 12.OR.ITYPE.EQ. 13.OR.ITYPE.EQ. 14) ) GO TO 10
                                                                                PAL 11890
                                                                                PAL11900
      IF (IMATCH. EQ. 1)
                        1CLOCK=1
      IF (IMATCH, EQ. 13) ITRST=I
                                                                                PAL 11910
   10 IPIN(I) = IMATCH
                                                                                PAL 11920
C
      ALL SIGNAL NAMES FOR THE FUNCTIONAL TEST HAVE BEEN READ IN
                                                                                PAL 11930
C
        ADJUST COUNT
                                                                                PAL 11940
   12 IMAX=I-1
                                                                                PAL 11950
      NVECT=0
                                                                                PAL 11960
                                                                                PAL 11970
C*****START OF MAIN LOOP FOR SIMULATION****
                                                                                PAL 11980
C
                                                                                PAL 11990
C
                                                                                PAL 12000
   90 IPCTR2=0
                                                                                PAL 12010
      IEQN=0
                                                                                PAL 12020
      IPCTR3=0
                                                                                PAL 12030
      LSA 12=, FALSE,
                                                                                PAL 12040
      LSA02= . FALSE.
                                                                                PAL 12050
C
                                                                                PAL 12060
      NVECT=NVECT+1
                                                                                PAL 12070
      IC1=0
                                                                                PAL 12080
      IL1=ILE
                                                                                PAL 12090
C
      GO PASSED COMMENT LINES
                                                                                PAL 12100
```

```
FILE: PAL24 FORTRAN A NSC FIME SHARING SERVICES VM/SP RELEASE 2.0
   23 IF (IPAGE (1, 1L) . NE. COMENT) GO TO 24
                                                                               PAL 12110
                                                                               PAL12120
      TL = TL + 1
      GO TO 23
                                                                               PAL 12130
   24 CONTINUE
                                                                               PAL 12140
C
      GETS VECTORS FROM FUNCTION TABLE
                                                                               PAL 12 15 0
      DO 20 I=1, IMAX
                                                                               PAL 12160
                                                                               PAL 12170
         IF (IPAGE (IC, IL) . EQ, IBLANK) GO TO 21
         GO TO 22
                                                                               PAL 12180
   21
         IC=IC+1
                                                                               PAL 12193
         IF (IPAGE (IC, 1L) . EQ. 18 LANK) GO TO 21
                                                                               PAL 12200
         IVECT(I) = IPAGE(IC, IL)
                                                                               PAL 12210
                                                                               PAL 12220
   20 CONTINUE
                                                                               PAL 12230
c
      ADVANCE LINE COUNT TO SKIP FUNCTION TABLE COMMENTS
                                                                               PAL 12240
      IL=IL+1
                                                                               PAL12250
      IC=1
                                                                               PAL 12260
      IF (IVECT (1), EQ, IDASH) GO TO 95
                                                                               PAL 12270
C
      CHECK FOR VALID FUNCTION TABLE VALUES (L, H, X, Z, C)
                                                                               PAL 12280
      DO 11 I=1, LMAX
                                                                               PAL 12290
                                                                               PAL 12300
          IF ( IVECT(I) .EQ.L.OR.IVECT(I) .EQ.H.OK.IVECT(I) .EQ.X.OR.
              IVECT (I) . EQ. 2. OR. IVECT (I) . EQ. C) GO TO 11
                                                                               PAL 12310
          Walte (PMS, 8) IVECT (1), NVECT
                                                                               PAL 12320
          FORMAT (/, ', A1, ' is NOT AN ALLOHED FUNCTION TABLE ENTRY',
                                                                               PAL 12330
                           ' IN VECTOR ',13)
                                                                               PAL 12340
                                                                               PAL12350
          RETURN
   11 CONTINUE
                                                                               PAL 12360
                                                                               PAL 12370
С
      INITIALIZE CLOCK AND THREE-STATE ENABLE FLAGS
      LCLOCK = . FALSE.
                                                                               PAL 12380
      LCTRST=. TRUE.
                                                                               PAL 12390
                                                                               PAL12400
      LPTRST=. IRUE.
      DO 13 I=1,IMAX
                                                                               PAL 12410
          LENABL (I) = . FRUE.
                                                                               PAL12420
C
      INITIALIZE NREG (NOT REGISTERED OUTPUT) TO FALSE
                                                                               PAL 12430
      NREG=.FALSE.
                                                                               PAL 12440
C
      INITIALIZE ISTATE ARRAY TO ALL X'S
                                                                               PAL 12450
      DO 15 I=1,24
                                                                               PAL 12460
   15 ISTATE(I) = X
                                                                               PAL 12470
C
      CHECK IF THIS PAL TYPE HAS REGISTERS
                                                                               PAL12480
      IF(..NOT.(ITYPE.EQ.8.OR.ITYPE.EQ.9.OR.ITYPE.EQ.10.OR.
                                                                               PAL 12490
                 ITYPE.EQ. 12.08. ITYPE.EQ. 13.08. ITYPE.EQ. 14) ) GO TO 25
                                                                               PAL 12500
C
      CHECK CLOCK AND THREE-STATE ENABLE PINS AND CHANGE FLAG IF NEEDED PAL 12510
      IF (IVECT (ICLOCK), EQ.C) LCLOCK=, TAUE,
                                                                               PAL 12520
      IF (ITRST. EQ. 0) GO TO 25
                                                                               PAL 12530
                     LPHASE (13)) . AND. (
                                             LPHASI (ITRST)).OR.
      LSAME= ( (
                                                                               PAL12540
               (.NOT.LPHASE(13)).AND.(.NOT.LPHASI(ITRST)))
                                                                               PAL 12550
      IF ( IVECT (IIRST) . EQ.L. AND. (. NOT. LSAME) .OR.
                                                                               PAL 12560
         IVECT (ITRST) . EQ. H. AND. ( LSAME) ) LPTRST=. FALSE.
                                                                               PAL 12570
                                                                               PAL12580
      IF (LPTRST) GO TO 25
                                                                               PAL 12590
С
      DISABLE REGISTERED OUTPUTS IF APPROPRIATE
      DO 46 I=1, IMAX
                                                                               PAL 12600
          J=IPIN(I)
                                                                               PAL12610
          IF (J.EV.17.OR.J.EV.18.OR.J.EV.19.OR.J.EV.20) LENABL(I) = FALSE, PAL12620
          IF ( (ITYPE, EQ. 8. OR, ITYPE, EQ. 9. OR, ITYPE, EQ. 12. OR,
                                                                               PAL 12630
               ITYPE.EQ. 13) .AND. (J.EQ. 16. OR. J. EQ. 21) ) LENABL (I) = .FALSE. PAL12640
          IF ( (ITYPE, EQ. 8. OR, ITYPE, EQ. 9. OR, ITYPE, EQ. 12) . AND.
                                                                               PAL 12650
```

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FILE: PAL24
                 FORTRAN
                               NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
               (J.EQ.15.OR.J.EQ.22) )
                                                             LENABL(I) = . FALSE. PAL 12660
          IF ( ITYPE, EQ. 8, AND, (J. EQ. 14, OR. J. EQ. 23) )
                                                           LENABL(I) = . FALSE. PAL12670
   46 CONTINUE
                                                                                  PAL12680
c
                                                                                  PAL 12690
C*****CAN THROUGH THE LOGIC ECUATIONS*****
                                                                                  PAL 12700
C
                                                                                  PAL 12710
      MAKE A DUMMY CALL TO INCE
C
                                                                                  PAL 12720
   25 CALL INCR (IC1, IL1)
                                                                                  PAL 12730
   26 CALL GETSYM(LBUF, IBUF, 1, IC1, IL1)
                                                                                  PAL 12740
       IF(LLEFT) GO TO 29
                                                                                  PAL 12750
   27 IF (.NOT. LEQUAL) GO TO 26
                                                                                  PAL 12760
c
                                                                                  PAL 12770
      IF (LEQUAL) IEQN=IEQN+1
                                                                                  PAL 12780
C
                                                                                  PAL 12790
C
       EVALUATE CONDITIONAL THREE-STATE PRODUCT LINE
                                                                                  PAL 12800
   29 IF (LEGUAL) GO TO 35
                                                                                  PAL 12810
       NREG= . TRUE .
                                                                                  PAL 12820
   33 CALL GETSYM(LBUF, IBUF, 1, IC1, IL1)
                                                                                  PAL 12830
      CALL MATCH (IINP, IBUF, ISYM1)
                                                                                  PAL 12840
       CHECK FOR GND, VCC, /GND, OR /VCC IN CONDITIONAL THREE-STATE
C
                                                                                  PAL 12850
C
      PRODUCT LINE
                                                                                  PAL 12860
      IF (IINP, NE, 0) GO TO 32
                                                                                  PAL 12870
      CALL MATCH (INATCH, IBUF, ISYM)
                                                                                  PAL 12880
      ILL=ILI
                                                                                  PAL 12890
      IF ( IMATCH . EQ. 12. AND. (LBUF (1)).Ok.
                                                                                  PAL 12900
           IMATCH.EQ. 24. AND. (.NOT.LBUF(1)) ) LCTRST=.FALSE.
                                                                                  PAL12910
      IF ( IINP.EQ.O. AND. IMATCH. NE. 12. AND. IMATCH. NE. 24 ) GO TO 100
                                                                                  PAL 12920
      GO TO 34
                                                                                  PAL 12930 '
   32 ITEST=IVECT (IINP)
                                                                                  PAL 12940
      IF ( ITEST. EQ. L. AND. (
                               LPHASI(IINP)), AND, (.NOT, LBUF(1))
LPHASI(IINP)), AND, (.NOT, LBUF(1))
                                                                                  PAL 12950
      1.OR. ITESI.EQ.H.AND. (
                                                                                  PAL 12960
     2.OR, ITEST.EQ.H.AND.(.NOT.LPHASI(IINP)).AND.( LBUF(1))
                                                                                  PAL12970
      3.OR. ITEST.EQ.L.AND. (.NOT.LPHASI(IINP)).AND. (.NOT.LBUF(1))
                                                                                  PAL 12980
     4 ) LCTRST= FALSE.
                                                                                  PAL 12990
      IF (ITEST. EQ. X.OR. ITEST. EQ. Z) LCThST=.FALSE.
                                                                               - PAL 13000
   34 IF (LAND) GO TO 33
                                                                                  PAL 13010
      GO TO 27
                                                                                  PAL 13020
                                                                                  PAL13030
C
       EVALUATE THE LOGIC EQUATION
                                                                               PAL 13040
C
                                                                                  PAL 13050
C
      FIND PIN NUMBER OF THE OUTPUT VECTORS
                                                                                  PAL 13060
С
                                                                                  PAL 13070
   35 IPCTR 3=0
                                                                                  PAL 13080
С
                                                                                  PAL 13090
      CALL MATCH (IOUTP, IBUF, ISYMI)
                                                                                  PAL 13 100
C
      FLAG FOR UNREGISTERED OUTPUTS
                                                                                  PAL13110
      CALL MATCH (IOUT, IBUF, ISYM)
                                                                                  PAL 13 120
      IF (ITYPE.LE. 7. OR. 1TYPE. EQ. 11) NREG=. TRUE.
                                                                                  PAL 13 130
      IF ( (ITYPE.EQ.9.OR.ITYPE.EQ.10).AND.(IOUT.EQ.14.OR.IOUT.EQ.23) )
                                                                                  PAL 13 140
                                                                                  PAL 13150
            NREG=.TRUE.
      IF ( (ITYPE, EQ. 10. OR. ITYPE, EQ. 13. OR. ITYPE, EQ. 14). AND.
                                                                                  PAL 13160
          - (IOUT.EQ. 15.OR. IOUT.EQ. 22) ) NREG=.TRUE.
                                                                                  PAL 13170
      IF ( (ITYPE, EQ. 10. OR, ITYPE, EQ. 14), AND, (IOUT, EQ. 16, OR, IOUT, EQ. 21) ) PAL 13 180
            NREG= . TRUE.
                                                                                  PAT. 13 190
    ILL=IL1
                                                                                  PAL 13200
```

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NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
FILE: PAL24
                FORTRAN A
                                                                               PAL 13210
      IF (IOUTP.EQ.O) GO TO 100
                                                                               PAL 13220
      IF (NREG) LENABL (IOUTP) = LCTRS [
                                                                               PAL 13230
      LOJT (IOUTP) = . TRUE.
                                                                               PAL 13240
      IF ( .NOT.LCTRST ) LOUT (IOUTP) = .FALSE.
                                                                               PAL 13250
      LCTRST = .THUE.
                                                                               PAL 13260
      LOUTP (IOUTP) = LBUF (1)
      DETERMINE PRODUCT TERM AND EVENTUALLY SUM FOR OUTPUT KEEPING
                                                                               PAL 13270
С
C
       TRACK TO SEE IF AN XOR (EXCLUSIVE OR) HAS BEEN FOUND
                                                                               PAL 13280
                                                                               PAL 13290
      XORSUM=H
                                                                               PAL 13300
      XORFND= FALSE.
                                                                               PAL 13310
      ISUM=L
                                                                               PAL 13320
С
                                                                               PAL13330
   28 IPCTR2=IPCTR2+1
      IPCTR3=IPCTR3+1
                                                                               PAL 13340
      IPCTR=IPCTR+1
                                                                               PAL 13350
С
                                                                               PAL 13360
                                                                               PAL 13370
      H = GOSST
   30 ILL=IL1
                                                                               PAL 13380
      CALL GETSYM(LBUF, 1BUF, 1, IC1, IL1)
                                                                               PAL 13390
                                                                               PAL 13400
      CALL MATCH (TIMP, IBUF, ISYMI)
      IF (IINP.NE.U) GO TO 47
                                                                               PAL 13410
                                                                               PAL 13420
      CALL MATCH (IMATCH, IBUF, ISYM)
      IF (IMATCH.NE. 12. AND. IMATCH. NE. 24) GO TO 100
                                                                               PAL 13430
                                                                               PAL 13440
С
      TWEEK FOR GND AND VCC IN PRODUCT LINE
      IF (IMATCH, EQ. 12) ITEST=L
                                                                               PAL 13450
      IF (IdaTCH.EQ.24) ITEST = H
                                                                               PAL13460
                                                                               PAL13470
      IINP=23
      LPHAS1(23) = .TRUE.
                                                                               PAL 13480
      SO TO 37
                                                                               PAL 13490
                                                                               PAL 13500
   47 ITEST=IVECT(IINP)
С
                                                                               PAL13510
      GET REGISTERED FEED BACK VALUES
                                                                               PAL 13520
      IP (NREG) GO TO 37
                                                                               PAL 13530
      CALL MATCH (IIFB, IBUF, ISYM)
                                                                               PAL13540
      IF ( (ITYPE.EQ.8.OR.ITYPE.EQ.9.OR.ITYPE.EQ.10.OR.ITYPE.EQ.12.OR.
            ITYPE.EQ. 13.OR. ITYPE.EQ. 14). AND. (IIFB.EQ. 17.OR. IIFB. EQ. 18.OR. PAL 13550
            IIFB.EQ.19.OR.IIFB.EQ.20) ) ITEST=IVECTP(IINP)
                                                                               PAL13560
      IF ( (ITYPE.EQ. d. OK. ITYPE.EQ. 9. OR. ITYPE.EQ. 12. OR. ITYPE.EQ. 13). AND. PAL 13570
           (IIFB.EQ. 16.OR. IIFB.EQ. 21) ) ITEST=IVECTP (IINP)
                                                                               PAL 13580
      IF ( (ITYPE, EQ. 8. OR, ITYPE, EQ. 9. OR, ITYPE, EQ. 12) AND.
                                                                               PAL13590
           (IIFB.EQ.15.OR.IIFB.EQ.22) ) ITEST=IVECTP(IINP)
                                                                               PAL13600
                                                                               PAL13610
      IF ( ITYPE, EQ. 8, AND. (IIFB, EQ. 14, OR, IIFB, EQ. 23) )
                                                                               PAL13620
                                           ITEST=IVECTP (IINP)
                                                                               PAL13630
   37 IF (ITEST. EQ. X. OR. ITEST. EQ. Z) ITEST=L
      IF ( ITEST.EQ.L.AND. ( LPHASI (IINP)).AND. (
                                                                               PAL13640
                                                             LBUF(1))
                                                                               PAL 13650
                                  LPHASI(IINP)).AND.(.NOT.LBUF(1))
      1.OR. ITEST.EQ.H.AND. (
                                                                               PAL 13660
     2.OR. ITESI.EQ.H.AND.(.NOT.LPHASI(IINP)).AND.( LBUF(1))
     3.OR. ITEST. EQ. L. AND. (.NOT. LPHASI(IINP)). AND. (.NOT. LBUF(1))
                                                                               PAL13670
       ) IPROD=L
                                                                               FAL 13680
                                                                               PAL 13690
С
                                                                               PAL 13700
       IF ((IPCTR2.EQ.IPCTR1).AND.(LSA11)) GO TO 110
                                                                               PAL13710
                                                                               PAL13720
   38 IF (LAND) GO TO 30
                                                                               PAL13730
С
                                                                               PAL13740
       IF ((IPCTR2, EQ. IPCTR1), AND, (LSA01)) GO TO 120
```

c

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FILE: PAL24
                 FORTHAN A
                               NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
  121 IF (ISUM.EQ.L.AND.IPROD.EQ.X) ISUM=X
                                                                                  PAL13760
      IF ( (ISUM.NE.H) .AND.IPROD.EQ.H ) ISUM=H
                                                                                  PAL13770
      CHECK FOR XOR (EXCLUSIVE OR) AND SAVE INTERMEDIATE VALUE -
                                                                                  PAL13780
                                                                                  PAL13790
      IF (.NOT.LXOR) GO TO 31
                                                                                  PAL13800
      XORSUM=15UM
                                                                                  PAL 13810
      XORFND= TRUE.
                                                                                  PAL 13820
      ISUM=L
      GO TO 28
                                                                                  PAL13830
                                                                                  PAL13840
   31 IF(LOR) GO TO 28
      IPCTR3=0
                                                                                 PAL13850
С
      IF END OF EQUATION HAS BEEN FOUND, DETERMINE FINAL SUM AND SAVE ITPAL13860
      IF (.NOT. XORFND)
                           ISTATT (IOUTP) = ISUM
                                                                                  PAL13670
      IF ( (XORFND) . AND. ((ISUM. EQ. L. AND. XORSUM. EQ. L) . OR.
                                                                                  PAL13880
                           (ISUM.EQ.H.AND.XORSUM.EQ.H)) ) ISTATT (IOUTP) =L
                                                                                  PAL13890
      IF ( (XORFND), AND, ((ISUM, EQ.H. AND, XORSUM, EQ.L), OR,
                                                                                  PAL13900
                                                                                  PAL13910
                           (ISUM.EQ.L.AND.XORSUM.EQ.H)) ) ISTATT (IOUTP) =H
      IF ( (XORFND), AND. (ISUM, EQ. X, OR, XORSUM, EQ. X) ) ISTATT (IOUTP) = X REGISTER DOES NOT CHANGE STATE IF NO CLOCK PULSE IS RECEIVED
                                                                                  PAL 13920
                                                                                  PAL 13930
С
      IF ( (LCLOCK) .OR. (NREG) ) GO TO 36
                                                                                  PAL13940
      LSAME = ( (
                        LOUTP (TOUTP)) . AND. (
                                                    LPHASI (IOUTP)).OR.
                                                                                  PAL13950
                  (.NOT.LOUTP(IOUTP)).AND.(.NOT.LPHAS1(IOUTP)).)
                                                                                  PAL 13960
      IF ( IVECTP (IOUTP) . EQ. L. AND. ( LSAME) ) ISTATT (IOUTP) = L
                                                                                  PAL13970
      IF ( IVECTP (IOUTP) . EQ. H. AND. (
                                            LSAME) ) ISTATT (IOUTP) =H
                                                                                  PAL13980
      IF ( IVECTP (IOUTP) .EQ.L.AND. (.NOT.LSAME) ) ISTATT (IOUTP) = H
                                                                                  PAL 13990
      IF ( IVECTP (IOUTP) . EO. H. AND. (.NOT. LSAME) ) ISTATT (IOUTP) = L
                                                                                  PAL14000
   36 NREG= , FALSE ,
                                                                                  PAL14010
c
      CHECK IF ALL EQUATIONS HAVE BEEN PROCESSED BY COMPARING CURRENT
                                                                                  PAL 14020
С
        LINE NUMBER WITH FUNCTION TABLE LINE NUMBER
                                                                                  PAL 14030
      IF (IDESC, NE. G. AND. IL1. LT. IFUNCT, AND. IL1. LT. IDESC. OR.
                                                                                  PAL14040
                                                                                  PAL 14050
          IDESC. EQ. O. AND .IL1 .LT .IFUNCT) GO TO 27
С
      DETERMINE OUTPUT LOGIC VALUES
                                                                                  PAL 14060
C
       COMPARE OUTPUTS TO SEE IF VECTOR AGREES WITH RESULTS
                                                                                  PAL 14070
                                                                                  PAL 14080
      DO 50 T=1, IMAX
      IF (.NOT. LOUT (I)) GO TO 50
                                                                                  PAL 14090
      IF (ISTATT (I) . EQ.X.AND.IVECT (I) . EQ.X) GO TO 50
                                                                                  PAL 14 100
                                                                                 . PAL 14 110
      LSAME = ( (
                       LOUTP(I)).AND.( LPHAS1(I)).OR.
                  (.NOI.LOUT?(I)).AND.(.NOT.LPHAS1(I)).)
                                                                                  PAL 14 120
      IMESS=40
                                                                                  PAL14130
      IF (ISTATT (I) . EQ.L. AND. IVECT (I) . EQ.L. AND. (. NOT. LSAME))
                                                                     IMESS=41
                                                                                  PAL 14 14 3
      IF (ISTATT (I), EQ.H. AND, IVECT (I), EQ.H. AND, (.NOT, LSAME))
                                                                     IMESS=42
                                                                                  PAL 14 150
                                                                                  PAL14160
      IF (ISTATT (I) .EQ.L.AND.IVECT (I) .EQ.H.AND. ( ...
                                                          LSAME))
                                                                     IMESS=42
      IF (ISTATT (I) . EQ.H. AND. IVECT (I) . EQ.L. AND. (
                                                           LSAME))
                                                                     IMESS=41
                                                                                  PAL14170
                                                                                  PAL 14 180
      IF( (
                 LENABL (I)) . AND . IV ECT (I) . EQ. Z )
                                                                     INASS=43
      IF ( (.NOT.LENABL(1)).AND.(LOUT(I)).AND.IVECT(I).NE.Z ) IMESS=44
                                                                                  PAL14190
      IF (IMESS. NE. 40) LERR= .TRUE.
                                                                                  PAL 14200
C
                                                                                  PAL 14210
      IF ((, NOT, LERR), AND, ((LSA 11), OR, (LSA 01))) : GO TO 50 -
                                                                                  PAL14220
      IF ( (LERR) . AND, ( (LSA 11) .OR. (LSA 01) )) GO TO 115
                                                                                  PAL14230
C
                                                                                  PAL 14240
      IF (IMESS. 20, 41) WRITE (PMS, 41) NVECT, (ISYM1 (J, I), J=1,8)
                                                                                  PAL 14250
   41 FORMAT (/, FUNCTION TABLE ERROR IN VECTOR , 13, PIN = , 8A1,
                                                                                  PAL 14260
                    EXPECT = H ACTUAL = L^{\bullet}
                                                                                 PAL14270
      IF (IMESS, EQ. 42) WRITE (PMS, 42) AVECT, (ISYM1(J, I), J=1,8)
                                                                                  PAL 14283
   42 FORMAT (/, FUNCTION TABLE ERROR IN VECTOR', 13, PIN = 1,841,
                                                                                 PAL 14290
                                                                                  PAL14300
                    EXPECT = L ACTUAL = H^*)
```

```
FILE: PAL24 FORTRAN A NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
                                                                                PAL 14310
      IF (IMESS. EQ. 43) WRITE (PMS, 43) NVECT, (ISYM1(J, I), J=1,8)
   43 FORMAT (/, FUNCTION TABLE ERROR IN VECTOR', 13, PIN =1,8A1,
                                                                                PAL 14320
              /. EXPECT = OUTPUT ENABLE ACTUAL = 21)
                                                                                PAL 14 330
      IF (IMESS. EQ. 44) White (PMS, 44) NVECT, (ISYM1(J, I), J=1,8), IVECT(I)
                                                                                PAL14340
   44 FORMAT (/, FUNCTION TABLE ERROR IN VECTOR , 13, PIN = , 8A1,
                                                                                PAL 14350
                    EXPECI = 2 ACTUAL = 1, A1)
                                                                                PAL14360
                                                                                PAL 14370
      IF ( (IMESS.NE.40) .AND. (PMS.EQ.6) ) ARITE (PMS.45) BEL
   45 FORMAT (1 1, A 1)
                                                                                PAL 14360
     · IF (1MESS.NE. 40) IVECT (1) = ERR
                                                                                PAL 14390
      IF (IMESS, NE. 40) NERR=NERR+1
                                                                                PAL 14400
                                                                                PAL 14410
   50 CONFINUE
      CHANGE THE ORDER OF VECTORS FROM THE ORDER OF APPEARANCE IN THE
                                                                                PAL 14420
С
        FUNCTION TABLE TO THAT OF THE PIN LIST AND TWEEK FOR OUTPUT
                                                                                PAL 14430
      DO 65 I=1,24
                                                                                PAL 14440
                                                                                PAL 14450
          DO 55 J= 1, IMAX
                                                                                PAL 14460
          IF (IPIN(J) NE.1) GO TO 55
                                                                                PAL 14470
          IF ( IVECT(J) .EQ.L. JR. IVECT(J) .EQ. H ) GO TO 51
                                                                                PAL 14460
          ISTATE (I) = IVECT (J)
                                                                                PAL 14490
          GO TO 65
                                                                                PAL 14500
          LSAME= ( (
                        LPHASE(I)).AND.(
                                               LPHASI(J)).OR.
   51
                                                                                PAL 14510
     1
                   ( ((L) | ZAHQL.TON.) .CNA. ((I) = ZAHQL.10N.)
                                                                                PAL 14520
          1F( ITYPE.EQ.5.AND.(I.E2.13.OR.1.EQ.19) )
                                                         LOUT (J) = . TRUE.
                                                                                PAL 14530
          IF ( (.NOP.LOUT(J)).AND.(
                                         LSAME) . AND.
                                                                                PAL 14540
     ١
                 IVECT(J).Ey.L)
                                                         ISTATE (I) = NO
          IF ( (.NOT.LOUT (J)) .ANL. (
                                         LSAME) . AND.
                                                                                PAL 14550
      1 -
                 IVECT (J) . EQ. h )
                                                         ISTATE (I) = N !
                                                                                PAL 14560
                                                                                PAL 14570
          IF ( (.NOT.LOUT(J)).AND. (.NOT.LSAME).AND.
                                                                                PAL 14580
      1
                 IVECT(J) .EQ.L )
                                                         ISTATE (I) = N 1
                                                                                PAL 14590
          IF ( (, NOT, LOUT (J)) . AND. (, NOT, LSAME) . AND.
      ١
                IVECT (J) .EQ.H )
                                                         ISTATE(I)=NO
                                                                                PAL 14600
                     LOUT (J)) . AND. (
                                         LSAME) . AND.
                                                                                PAL 14610
          17((
                                                                                PAL 14620
      1
                 IVECT (J) .EQ.L.AND. (
                                           LENAUL(J)) | ISTATE(I) = L
          IF( (
                     LOUT (J) ) . AND. (
                                          LSAME) .AND.
                                                                                PAL 14630
                 IVECT (J) . EQ. H. AND. (
                                           LENABL(J)) | ISTATE(I) = H
                                                                                PAL 14640
          IF ( (
                     LOUT (J)) .AND. (.NOT.LSAME) .AND.
                                                                                PAL 14650
                 IVECT (J) .EQ.L.AND. (
                                                                                PAL 14650
      ١
                                          LENABL(J)) ) ISTATE(I)=H
                     LOUT (J)) . AND. (.NOT.LSAME) . AND.
                                                                                PAL 14670
                                                                                PAL 14680
                 IVECT (J), EQ. H. AND. (LENABL(J)) ISTATE (I) = L
          If ( IVECT(J).EQ.ERR )
                                                                                PAL 14690
                                                          15TATE (1) = ERR .
                                                                                PAL 14700
          GO TO 65
   55 CONTINUE
                                                                                PAL 14710
      SAVE PRESENT VECTORS FOR FEED BACK USED WITH NEXT SET OF VECTORS PAL14720
С
       IF CLOCK PULSE AND NOT Z (HI-Z IS ASYNCHRONOUS)
                                                                                PAL 14730
C
   55 IF ( (LCLOCK) .AND.IVECT(J) .NE.Z ) IVECTP(J) = IVECT(J)
                                                                                PAL 14740
С
      ASSIGN X TO GROUND PIN AND 1 TO VCC PIN
                                                                                PAL 14750
      ISTATE (12) = X
                                                                                PAL 14760
                                                                                PAL 14770
      ISTATE (24) = HI
С
      PRINT TEST VECTORS
                                                                                PAL 14780
      IF((.NOT.LSA11).AND.(.NOT.LSA01))WRITE(POF,60)
                                                                                PAL 14790
                                                                                PAL 14800
                                 NVECT, (ISTATE (I), I=1,24)
   60 FORMAT (' ', 13, ' ', 24A1)
                                                                                PAL 14810
                                                                                PAL 14820
      GO TO 90
```

PAL 14840

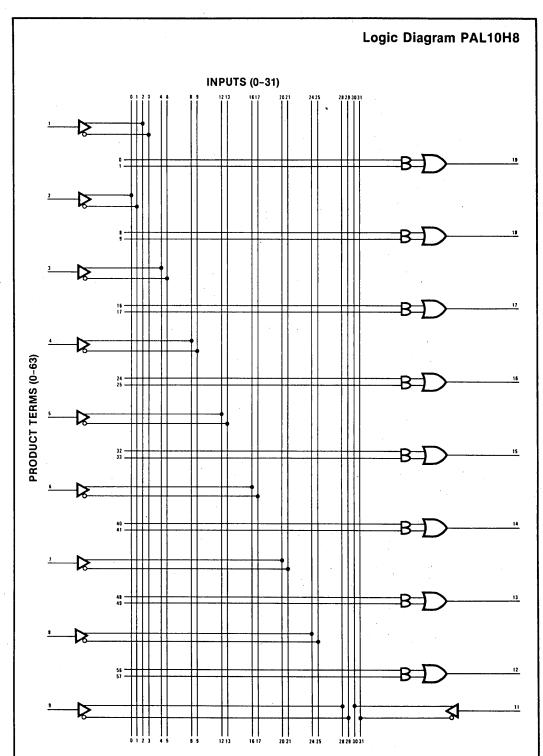
2AL14850

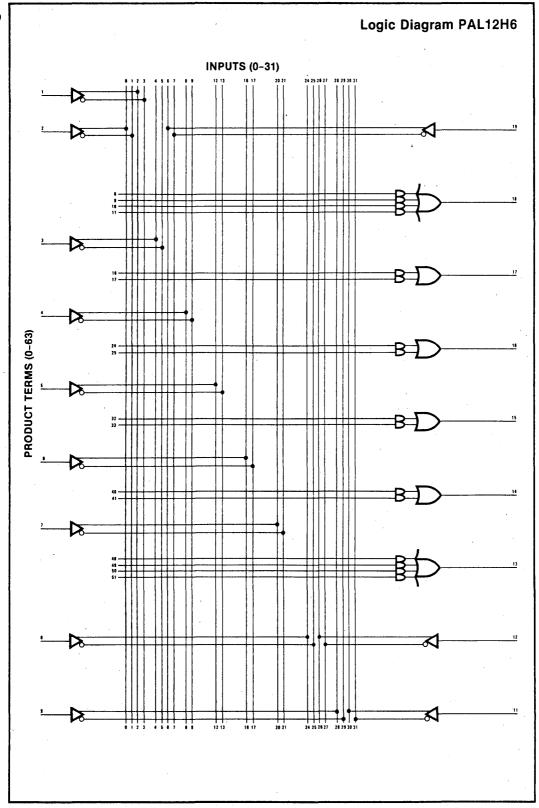
95 IF ((.NOT.LERR).AND. (LSA11)) WRITE (POF, 150) IPCTR4. IEQN1

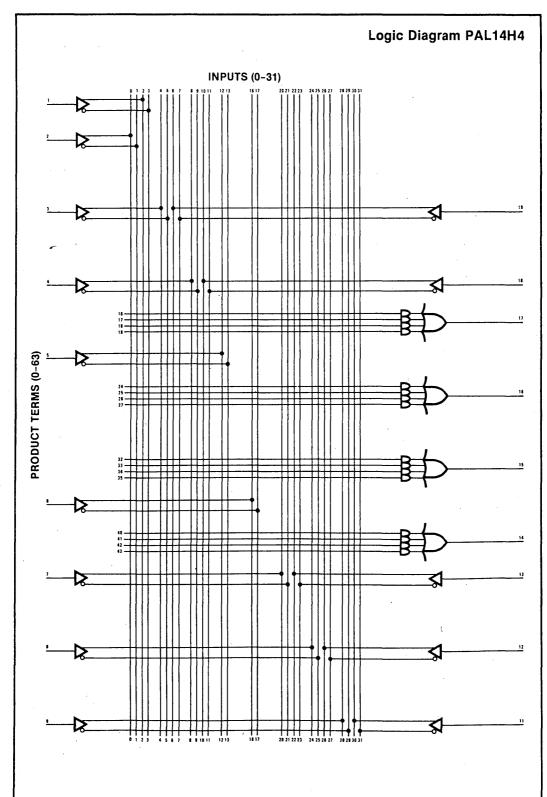
TERMINATE SIMULATION

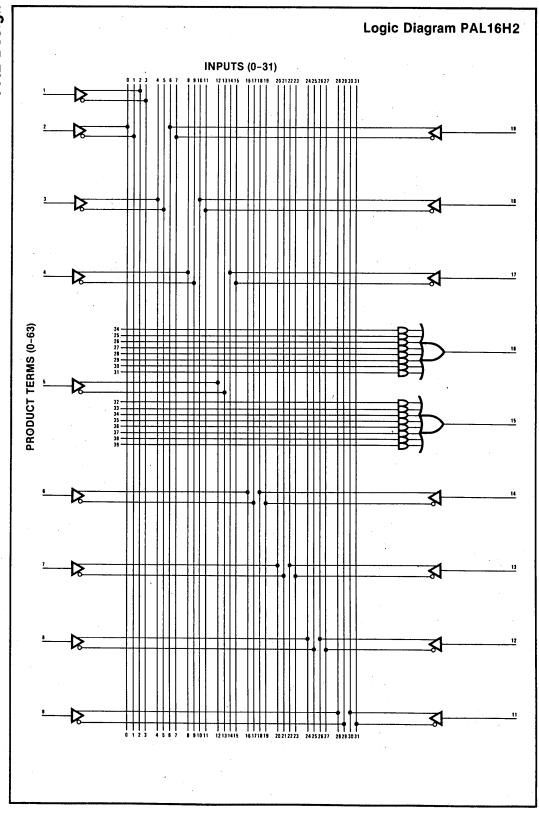
С

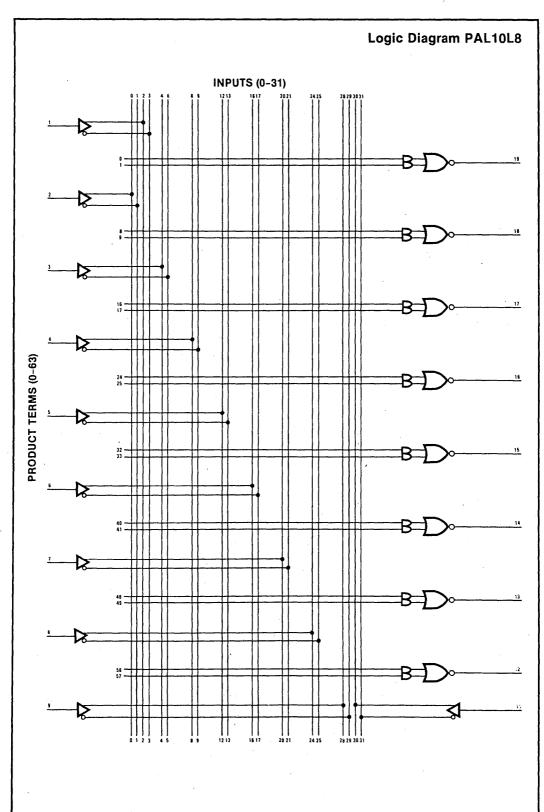
```
FILE: PAL24
                 FORTRAN
                                NSC TIME SHARING SERVICES VM/SP RELEASE 2.0
  150 FORMAT(' ', ' PRODUCT: ', 13, ' OF ', 'EQUATION', 13, '
                                                                                   PAL 14860
      1 UNTESTED (SA1) FAULT')
                                                                                   PAL 14870
  IF((.NOT.LERR).AND.(LSAGI)) WRITE(POF, 155) IPCTR4, IEQNI 155 FORMAT(* 1, * PRODUCT: 4, 13, * CF *, * EQUATION*, 13, *
                                                                                   PAL 14880
                                                                                   PAL 14890
      1 UNTESTED (SAO) FAULT')
                                                                                   PAL 14900
C
                                                                                   PAL 14910
       IF ((,NOT, LERR), AND. ((,NOT, LSA 11), AND. (,NOT, LSA 01))) WRITE (POF, 67) PAL 14920
   67 FORMAT (/, PASS SIMULATION')
                                                                                    PAL 14930
       IPCTR=IPCTR/(NVECT-1)
                                                                                   PAL 14940
      LF((
                LERK) .AND. ((.NOT.LSAII) .AND. (.NOT.LSAOI)))
                                                                                   PAL 14950
      IMPITE (POF, 68) NERR
                                                                                   PAL 14950
   68 FORMAT (/, NUMBER OF FUNCTION TABLE ERRORS = 1, 13)
                                                                                   PAL 14970
      RETURN
                                                                                   PAL14980
      PRINT AN ERROR MESSAGE FOR AN UNDEFINED PIN MAME
                                                                                   PAL 14990
  100 ILER#=1LL+4
                                                                                   PAL 15000
      #RITE (PMS, 101) (IBUF (1, 1), i=1,8), ILERR, (IPAGE (I, ILL), i=1,80) >
                                                                                   PAL 15010
  101 FORMAT (/, ' ERROR SYMBOL = ', BAI,' IN LINE NUMBER ', I3,
                                                                                   PAL 15020
              /,' ',80A1,/,' THIS PIN NAME IS NOT DEFINED IN THE',
                                                                                   PAL 15030
                              ' FUNCTION TABLE PIN LIST')
                                                                                   PAL 15040
      REPURN
                                                                                   PAL 15050
                                                                                   PAL 15060
  110 1PR00=8
                                                                                   PAL 15073
      LSA12= TRUE.
                                                                                   PAL 15060
    · TEONIELEON
                                                                                   PAL 15090
      IPCTR4=IPCTR3
                                                                                   PAL 15 100
      .GO TO 38
                                                                                   PAL 15 110
C
                                                                                   PAL 15120
C
                                                                                   PAL15130
С
                                                                                   PAL 15 140
  12C IPROD=L
                                                                                   2AL 15 150
      LSAG2=.TRUE.
                                                                                   PAL 15 160
      IEQNI=IEQN
                                                                                   PAL 15 170
      IPCTR4=IPCTR3
                                                                                   PAL 15180
      GO TO
                 121
                                                                                   PAL 15 190
С
                                                                                   PAL 15200
С
                                                                                   PAL 15210
C
                                                                                   PAL 15220
  115 ISAF=ISAF+1
                                                                                   PAL 15230
      LERR= . FALSE.
                                                                                    PAL 15240
      RETURN
                                                                                   PAI. 15250
c
                                                                                   PAL 15260
       END
                                                                                   PAL 15270
```

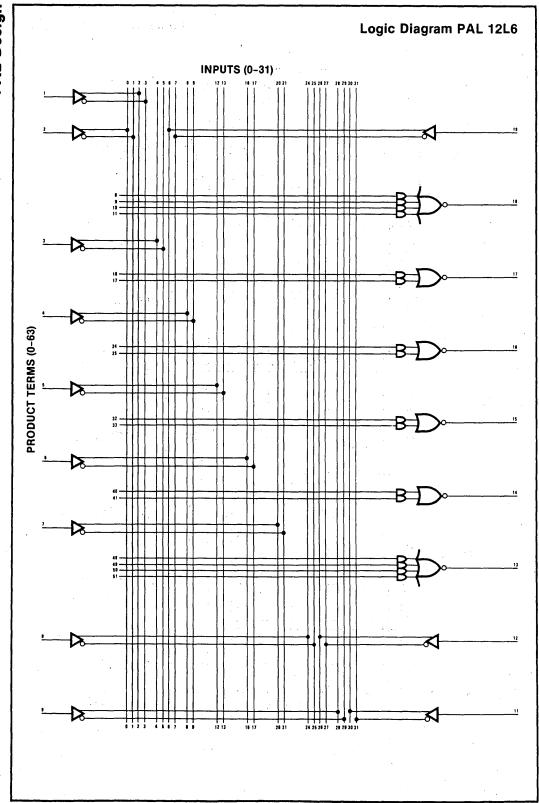


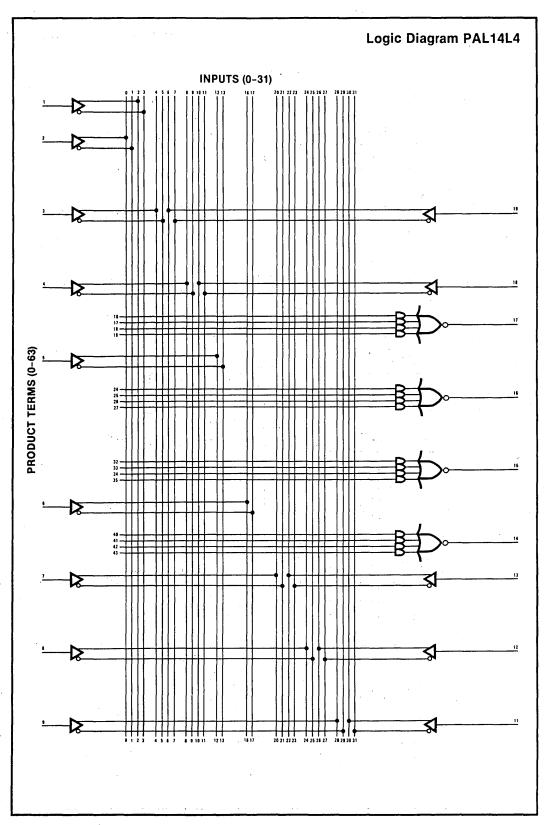


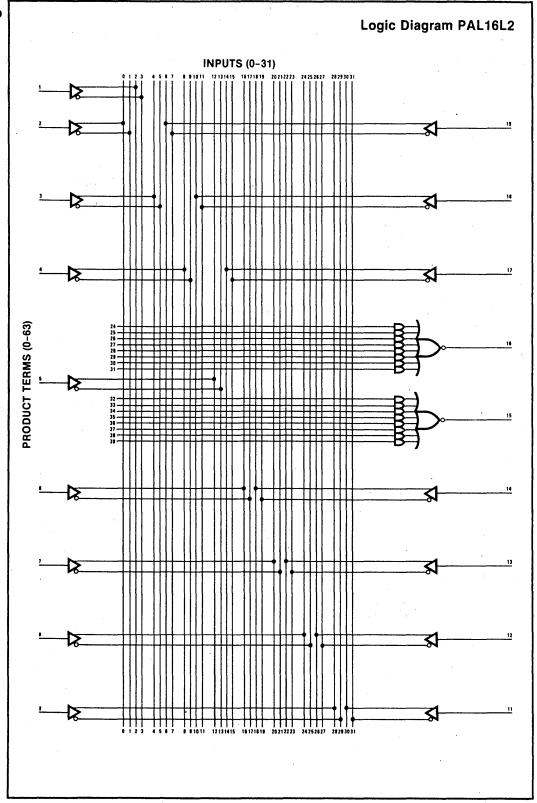


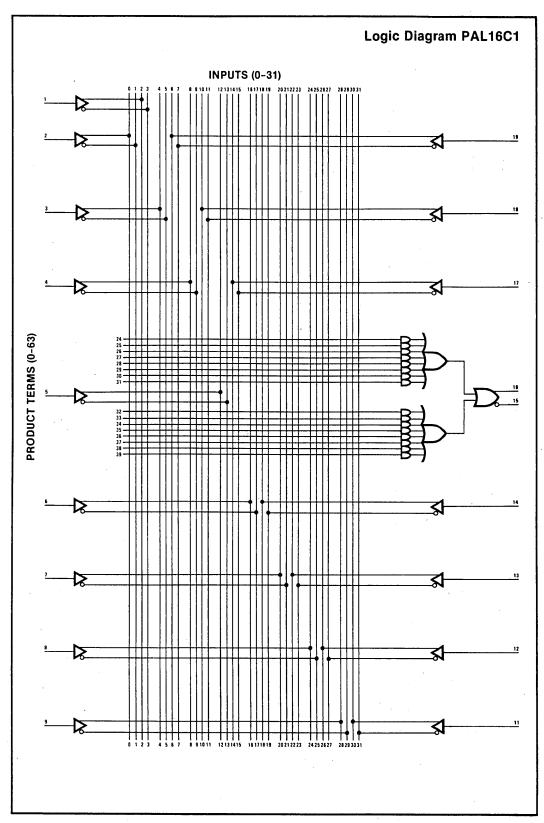


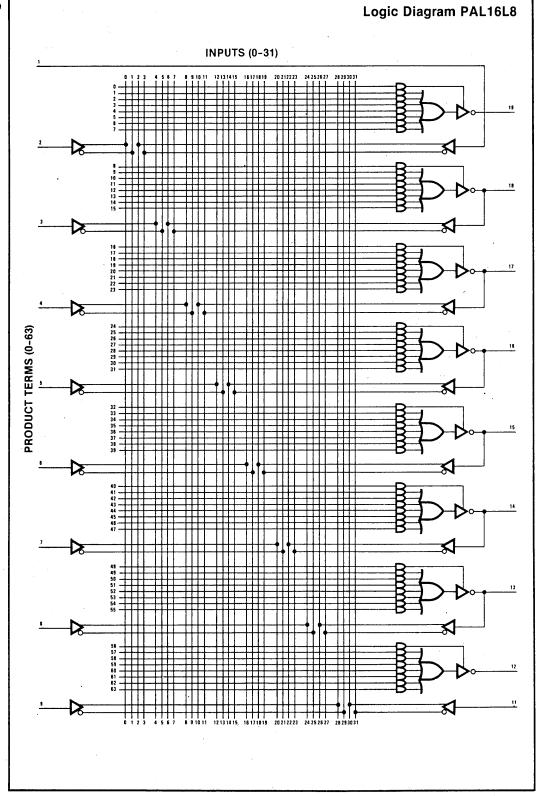


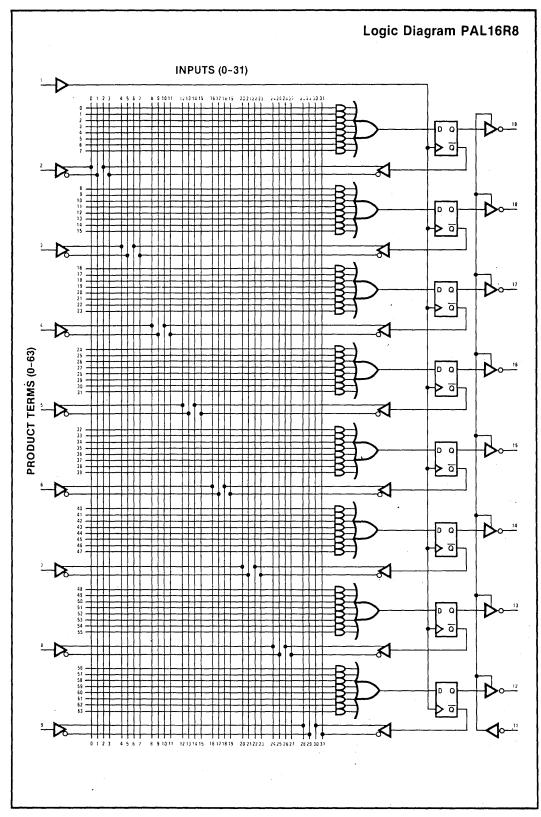




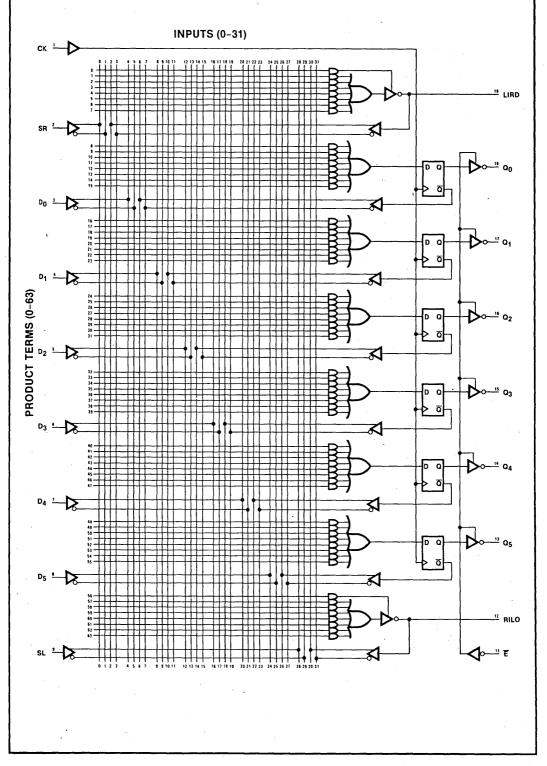


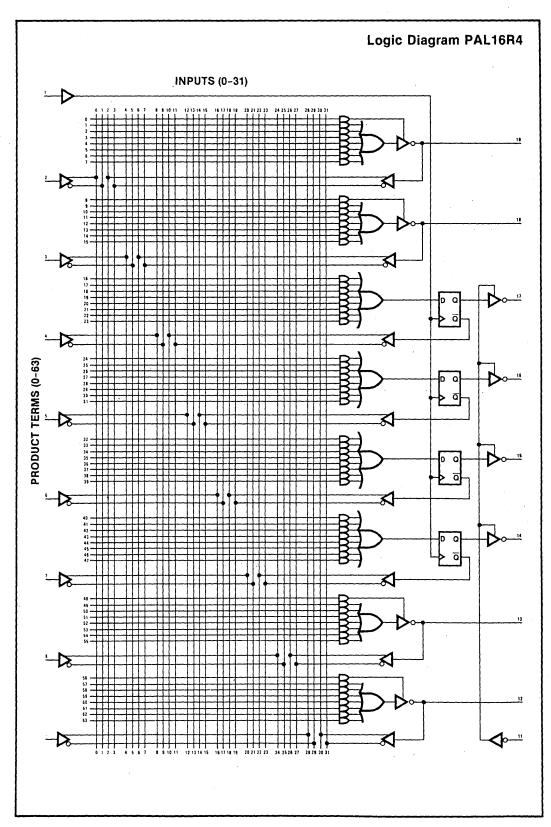


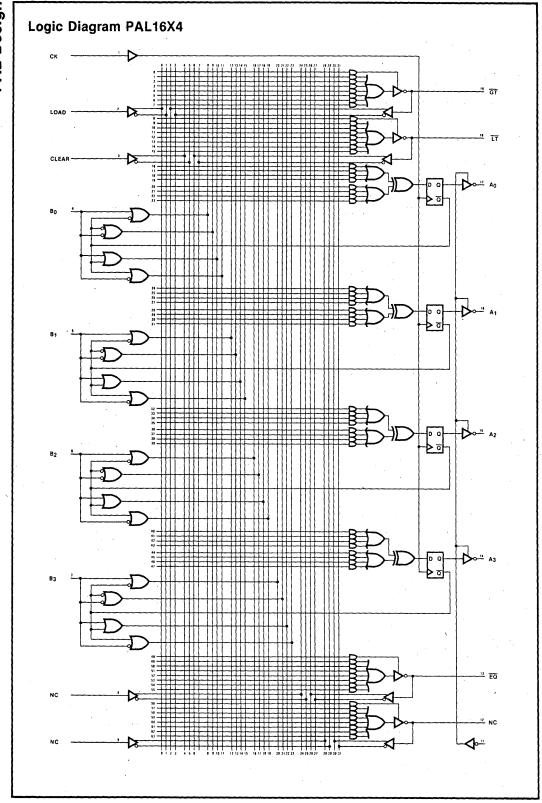


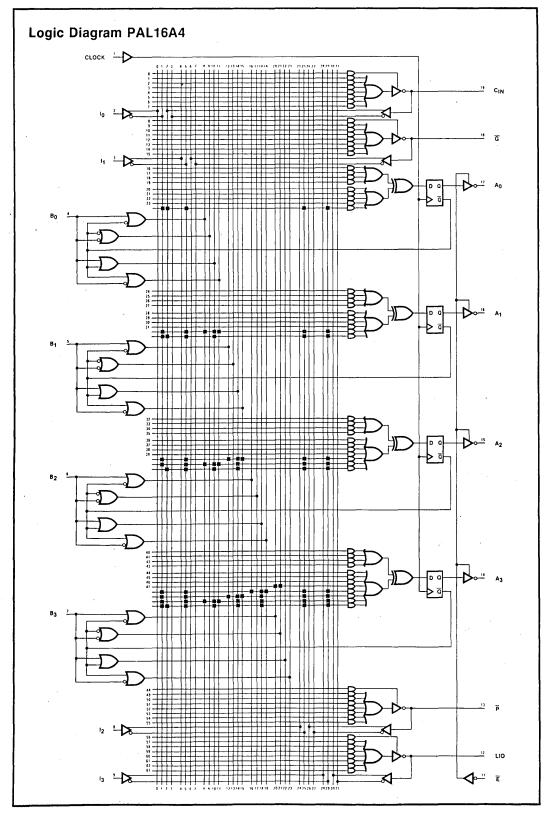


## Logic Diagram PAL16R6

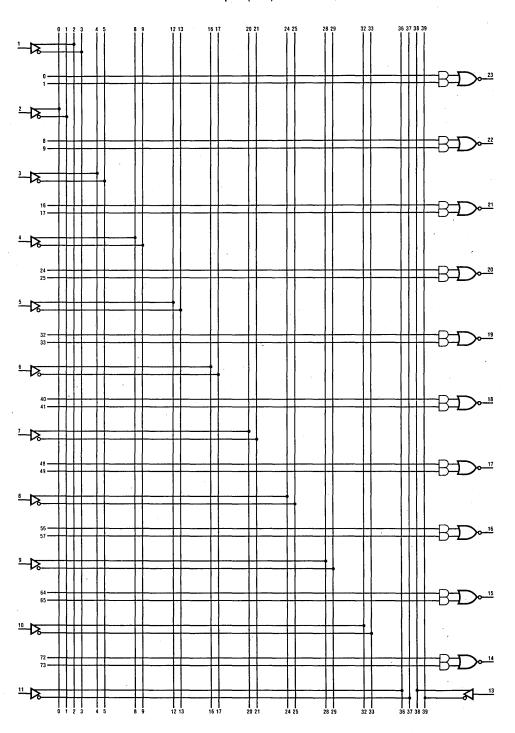




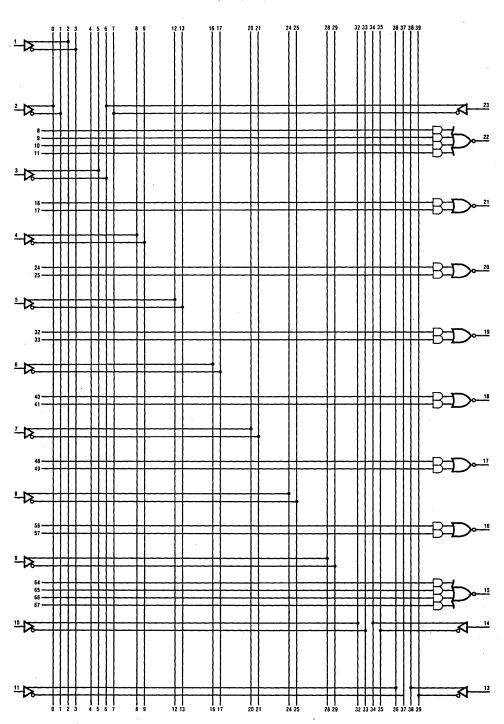




Inputs (0-39)



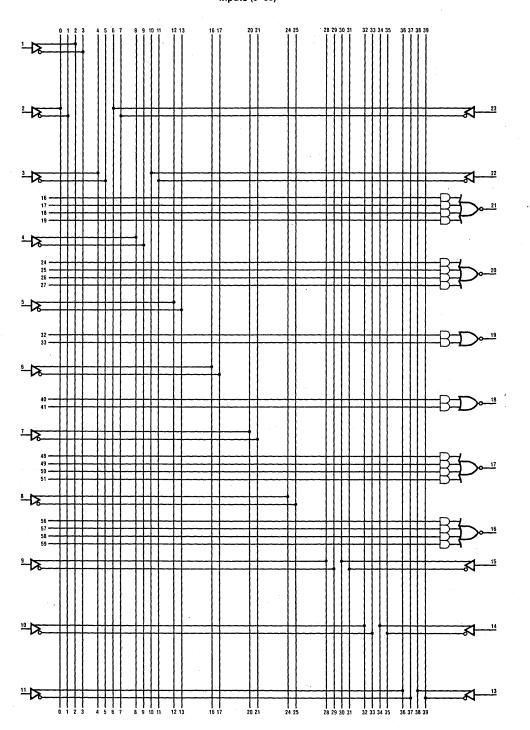
Inputs (0-39)



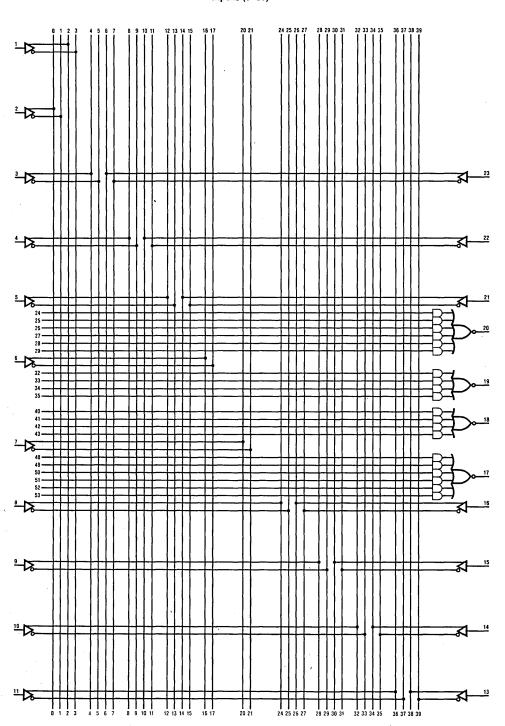
**Logic Diagram** 

DMPAL16L6

Inputs (0-39)

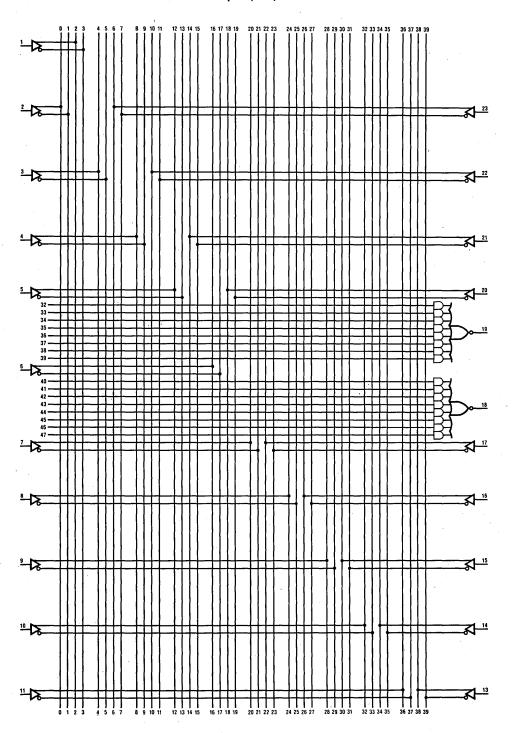


Inputs (0-39)



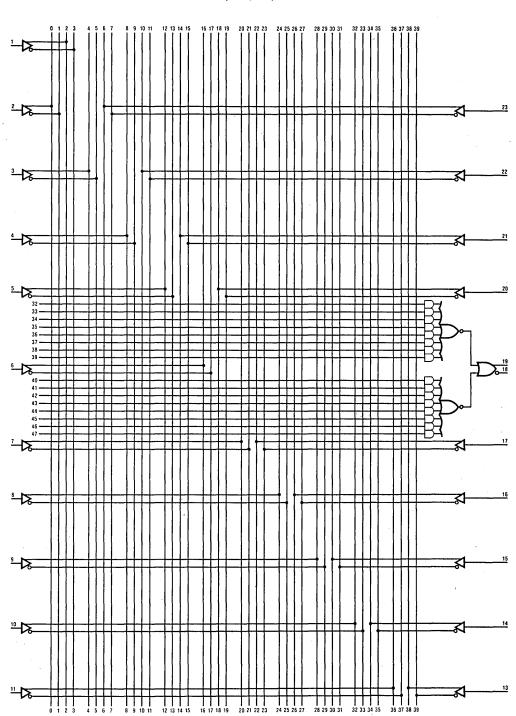
## DMPAL20L2

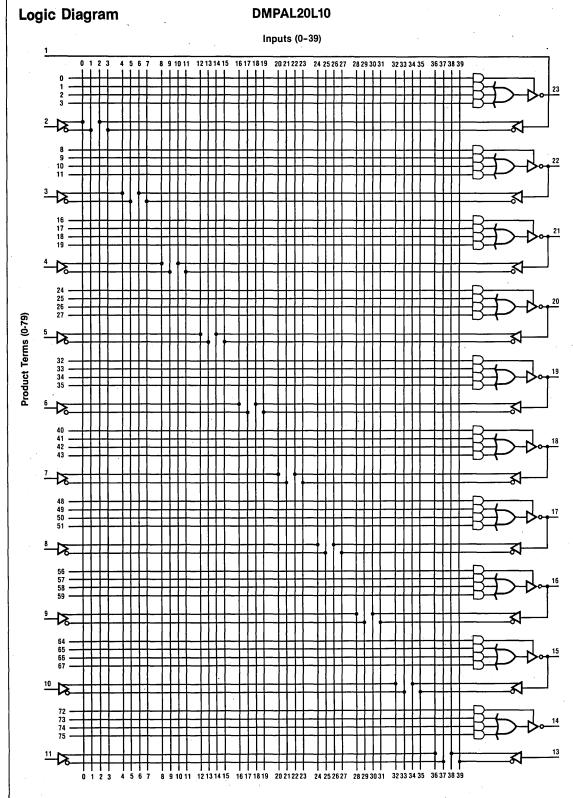
Inputs (0-39)

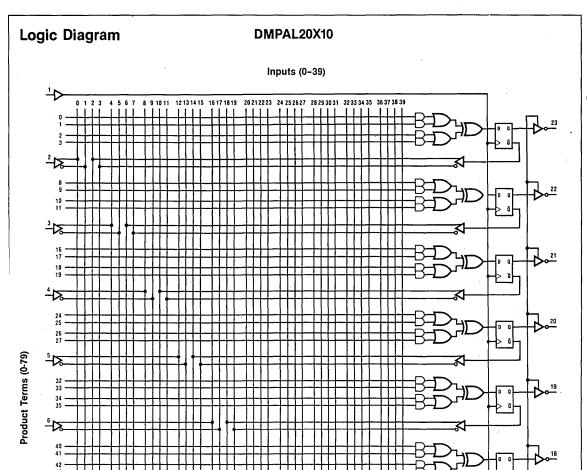


DMPAL20C1

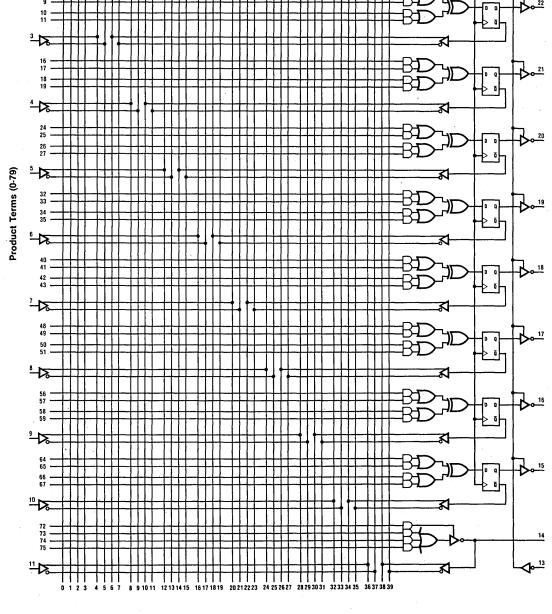
Inputs (0-39)







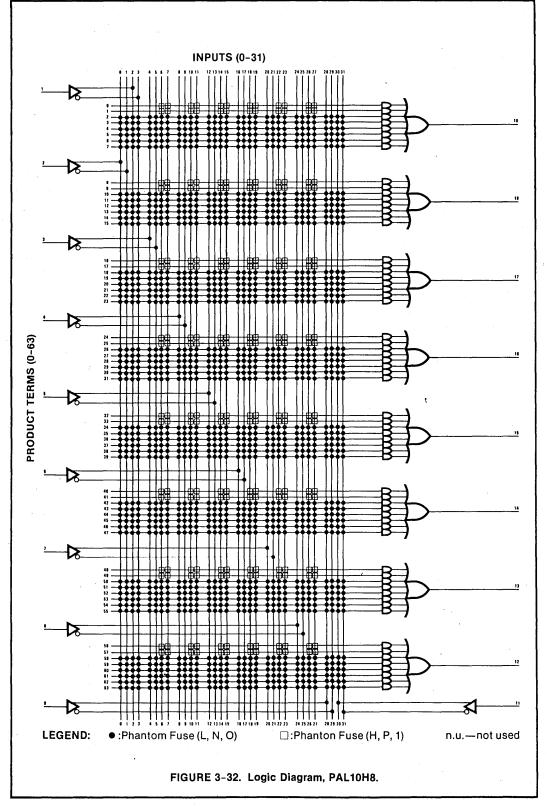
<u>"</u>|**>**₀



Inputs (0-39) 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27 28 29 30 31 32 33 34 35 36 37 38 39 23 22 24 -25 -Product Terms (0-79) 16 <del>11</del> De



PAL LOGIC DIAGRAMS AND PROGRAMMING FORMAT CODING SHEETS FOR PAL 20 SERIES



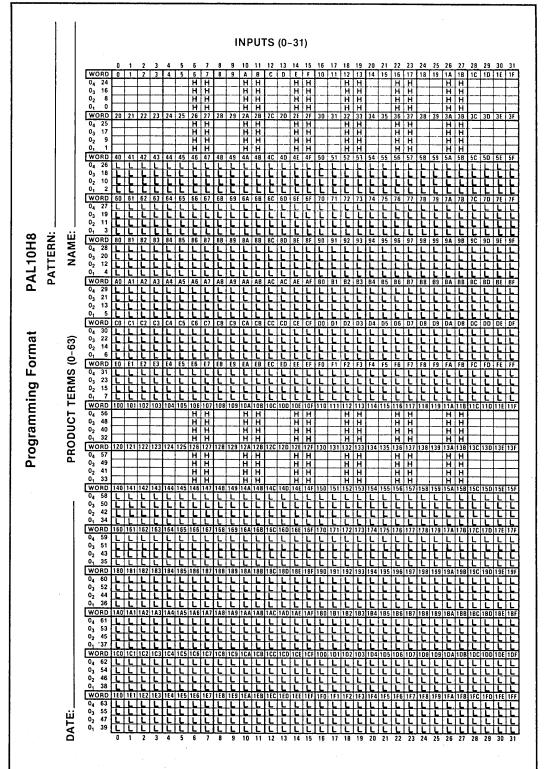
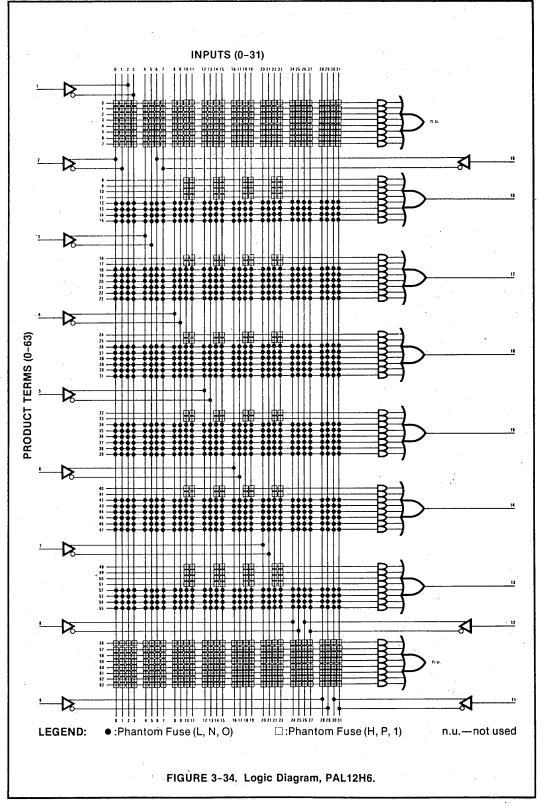


FIGURE 3-33. Programming Format Sheet, PAL10H8.



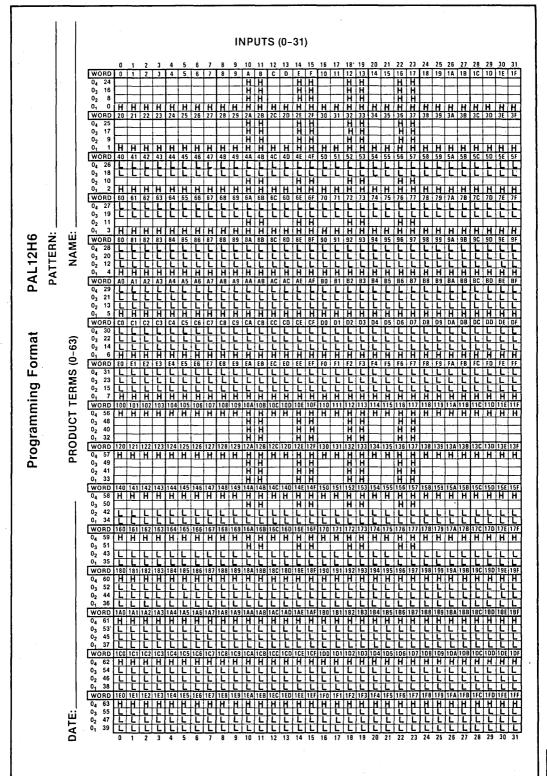
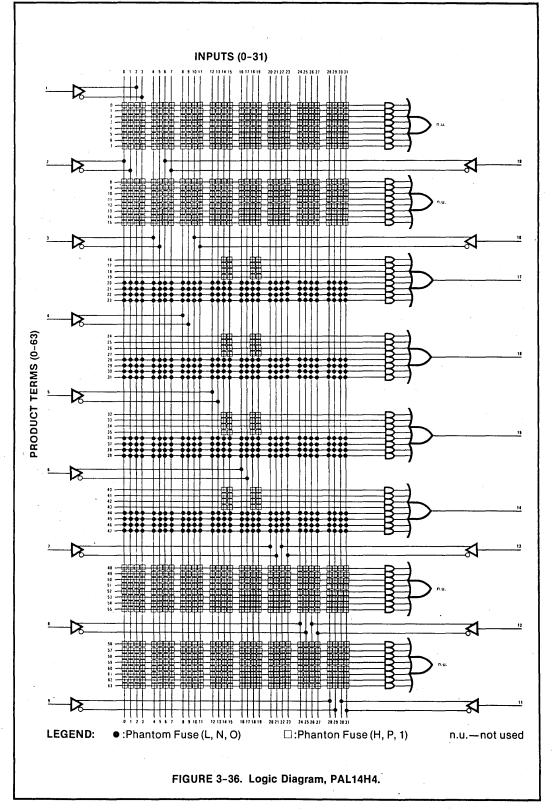


FIGURE 3-35. Programming Format Sheet, PAL12H6.



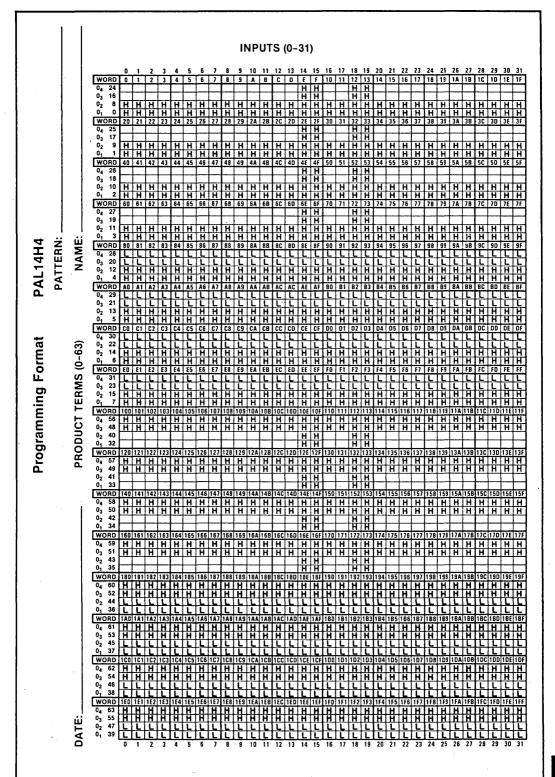
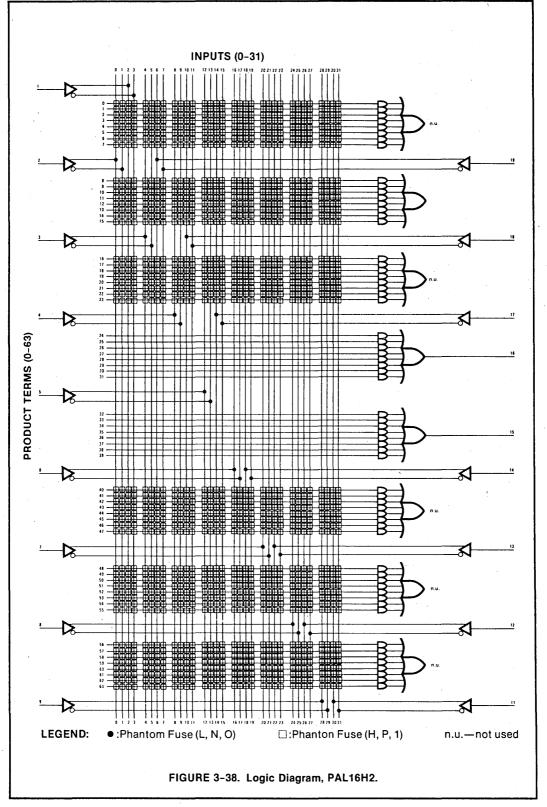


FIGURE 3-37. Programming Format Sheet, PAL14H4.



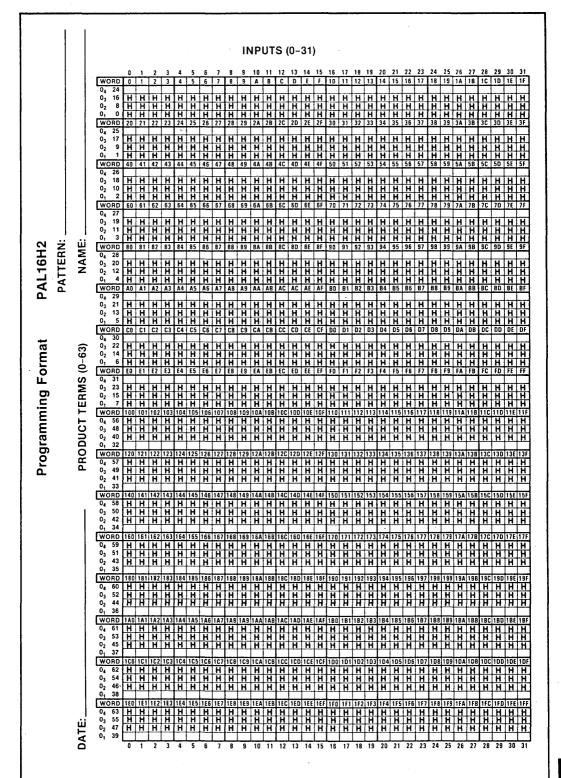
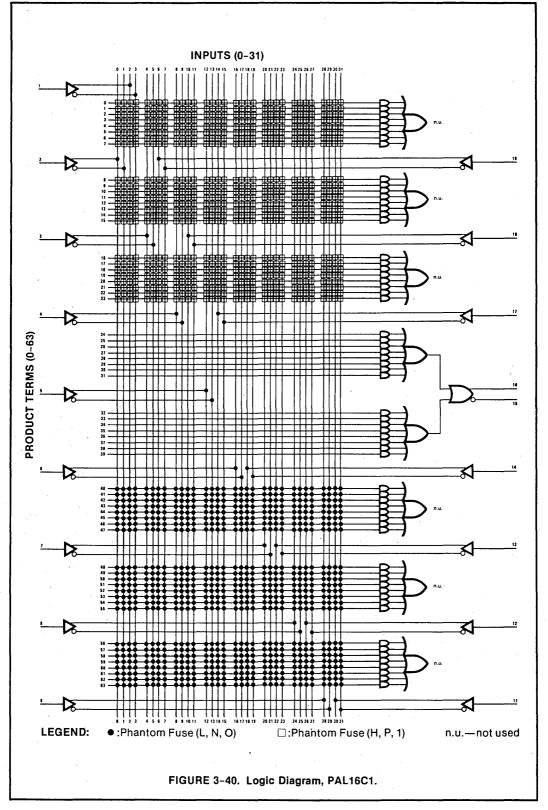


FIGURE 3-39. Programming Format Sheet, PAL16H2.



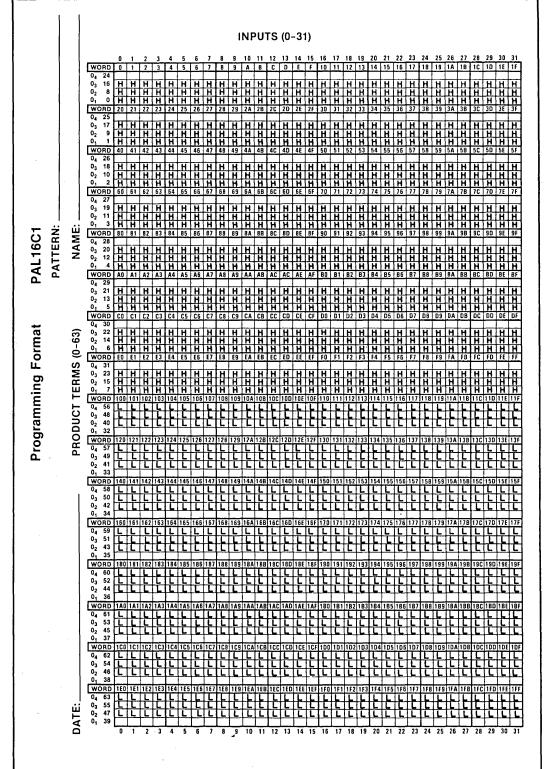
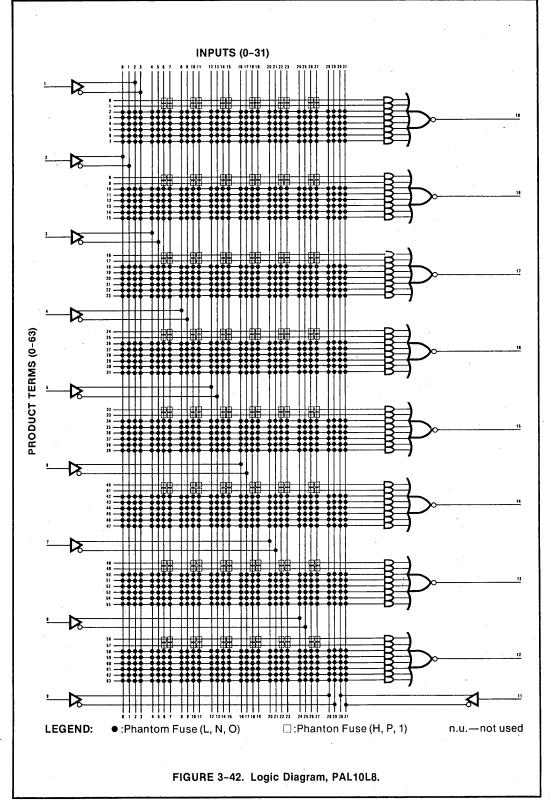


FIGURE 3-41. Programming Format Sheet, PAL16C1.



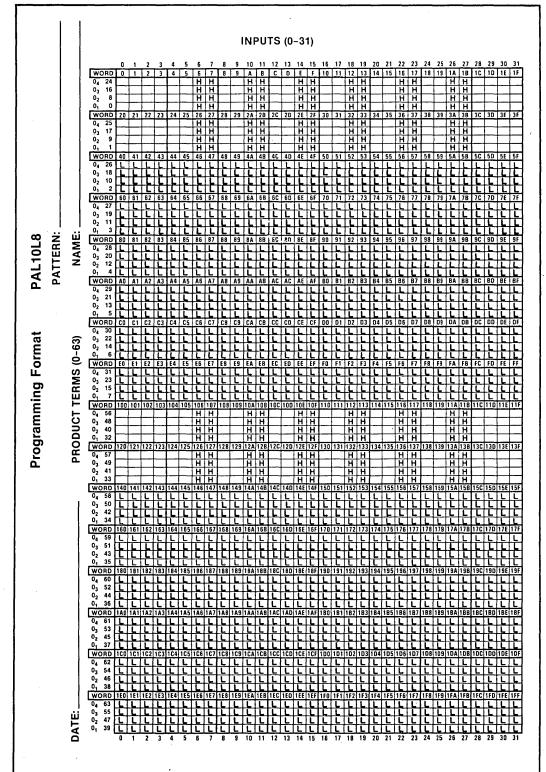
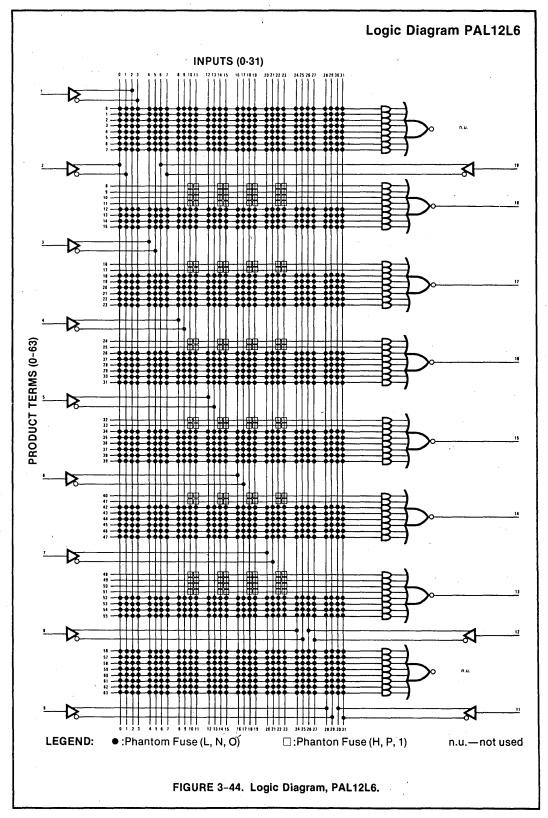


FIGURE 3-43. Programming Format Sheet, PAL10L8.



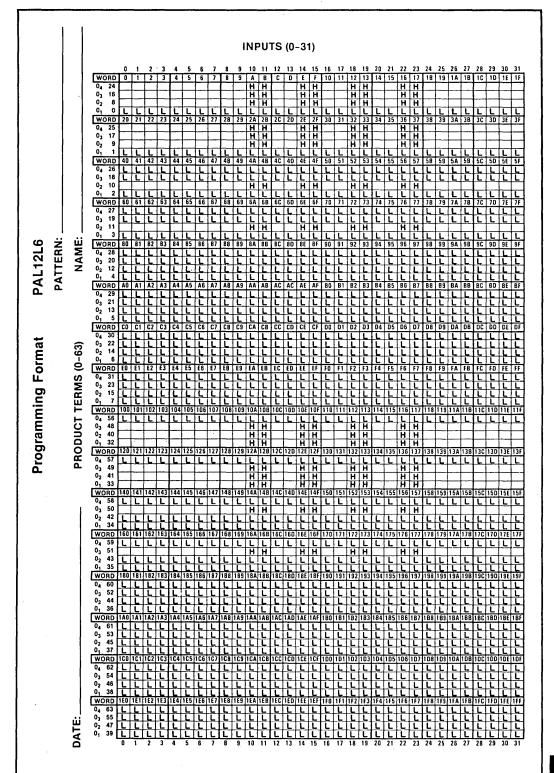
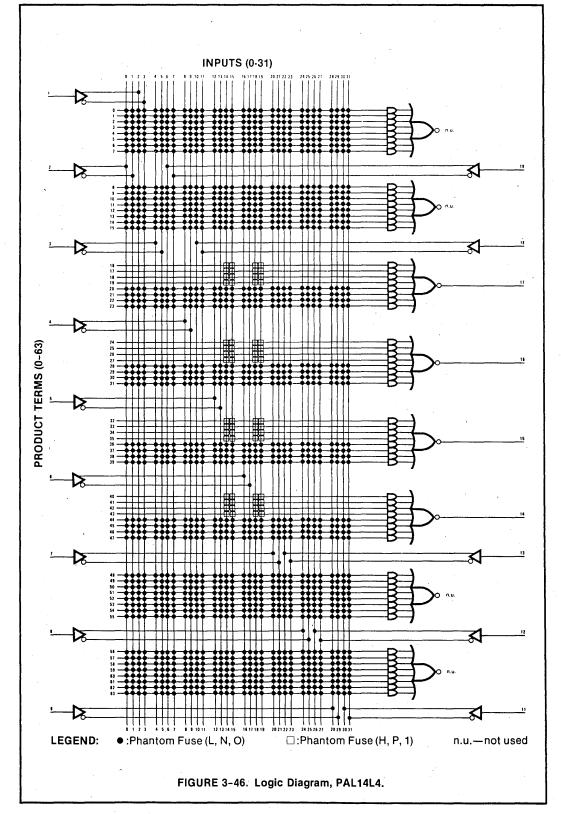


FIGURE 3-45. Programming Format Sheet, PAL12L6.



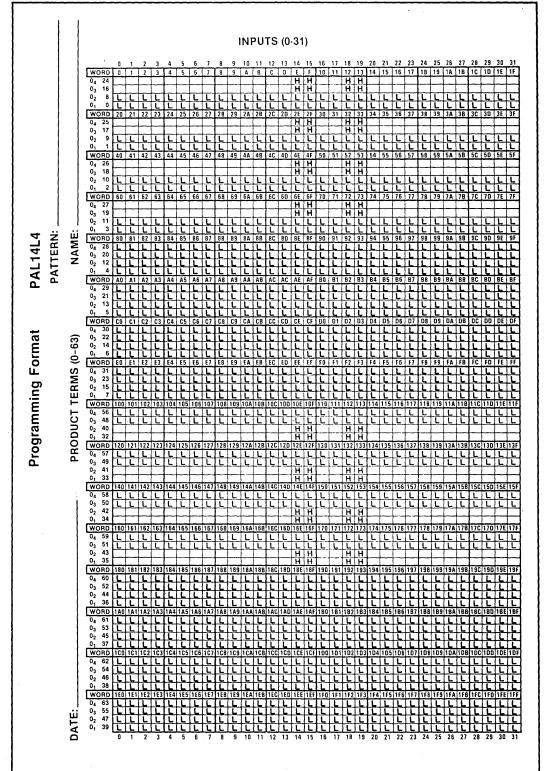
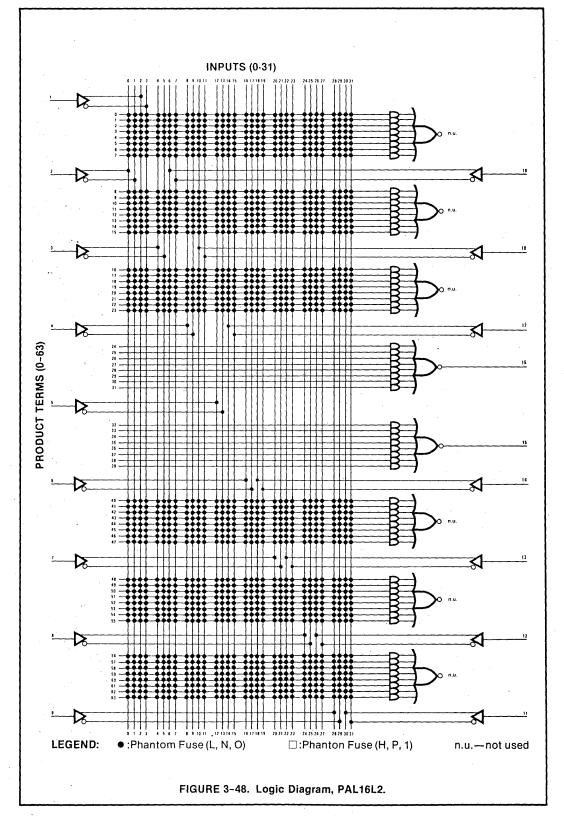


FIGURE 3-47. Programming Format Sheet, PAL14L4.



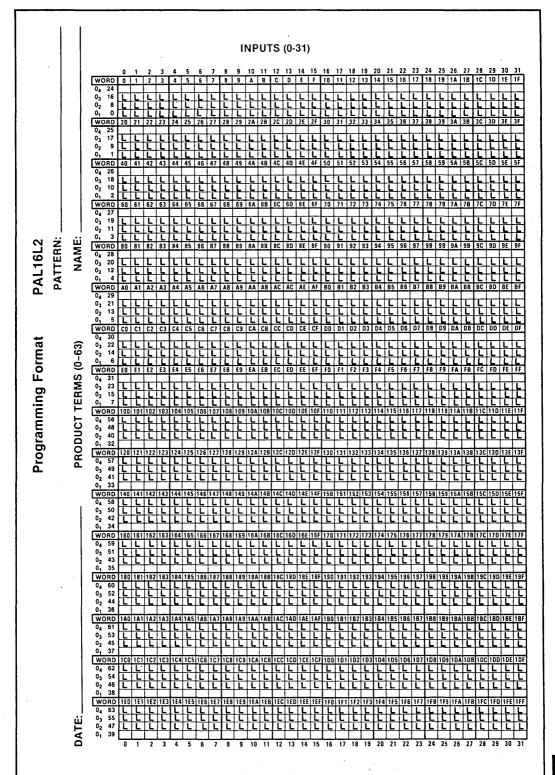
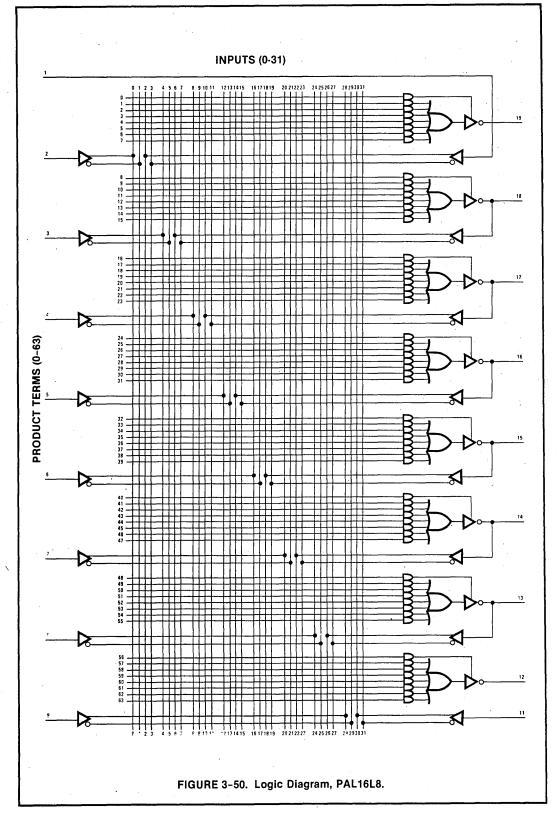


FIGURE 3-49. Programming Format Sheet, PAL16L2.



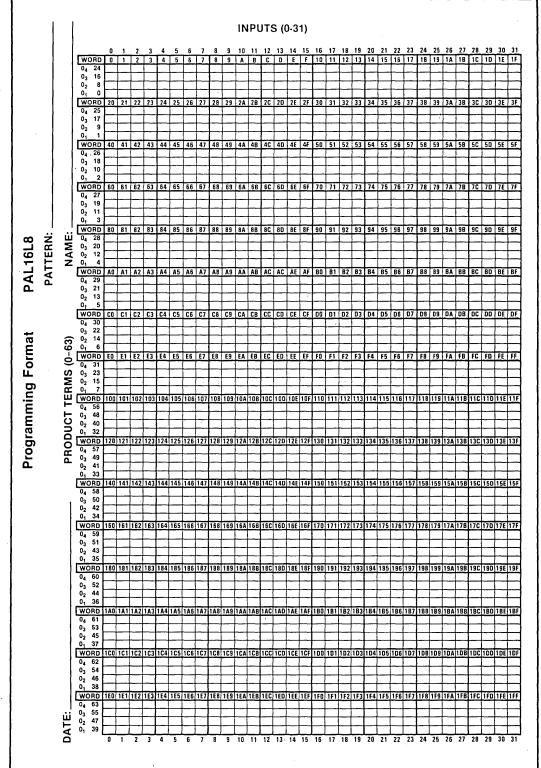
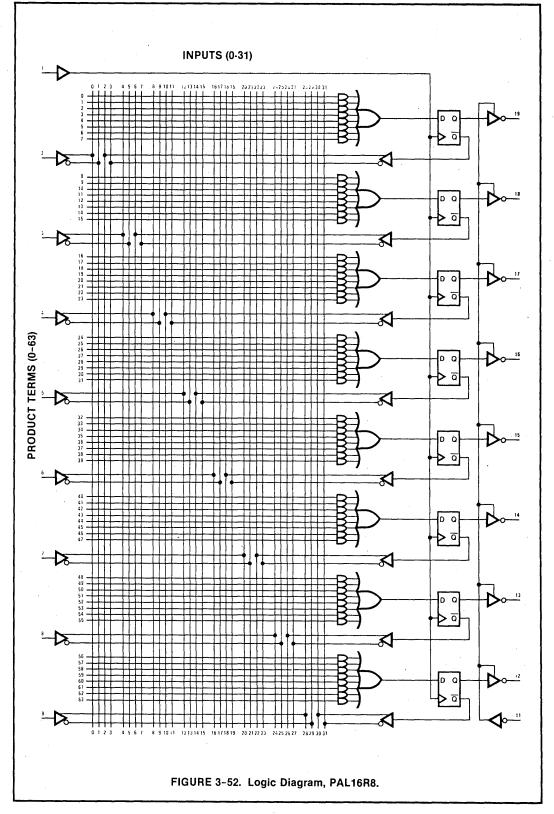


FIGURE 3-51. Programming Format Sheet, PAL16L8.



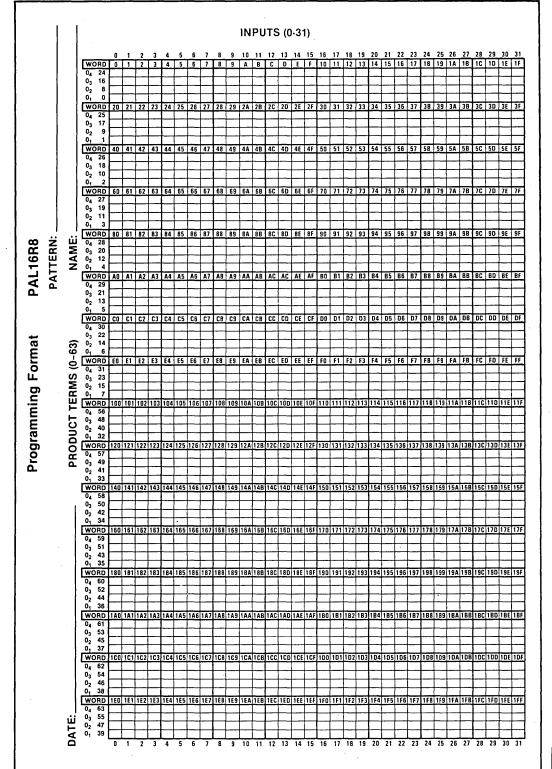
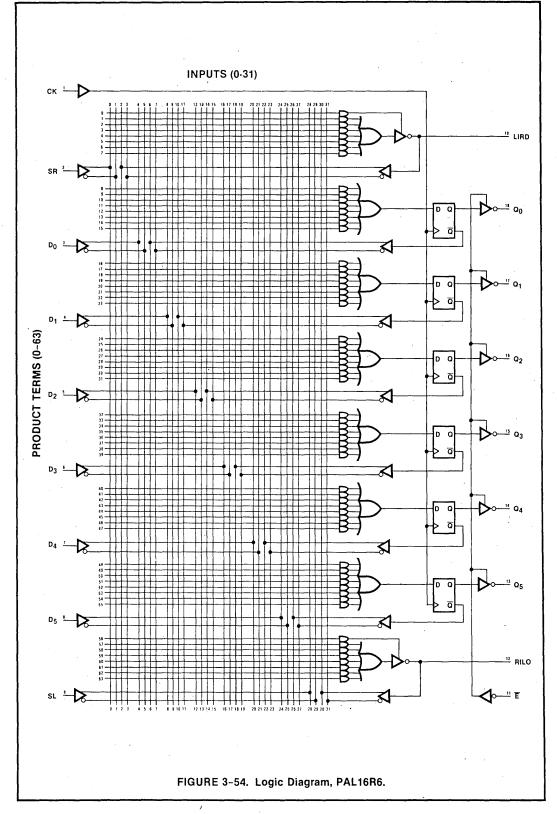


FIGURE 3-53. Programming Format Sheet, PAL16R8.



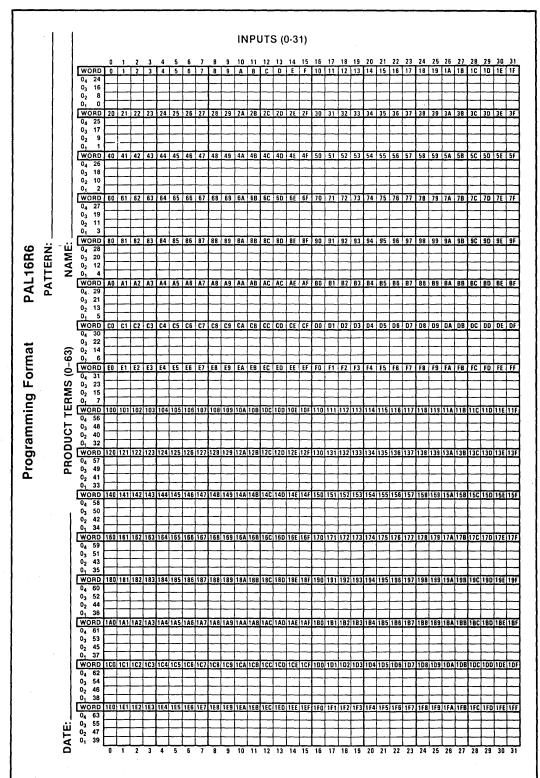
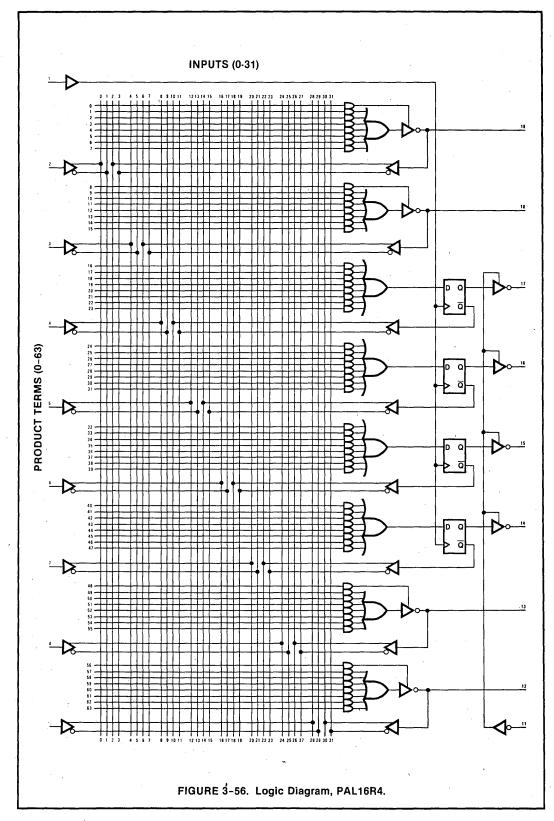


FIGURE 3-55. Programming Format Sheet, PAL16R6.



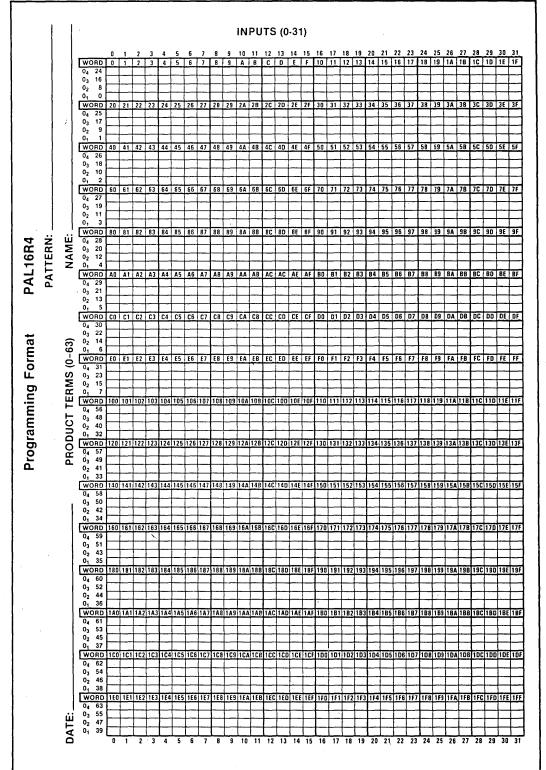
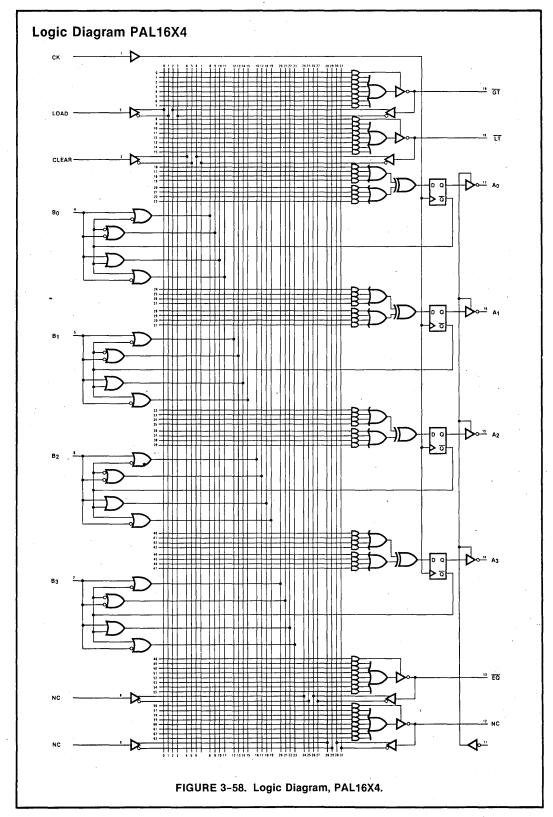


FIGURE 3-57. Programming Format Sheet, PAL16R4.



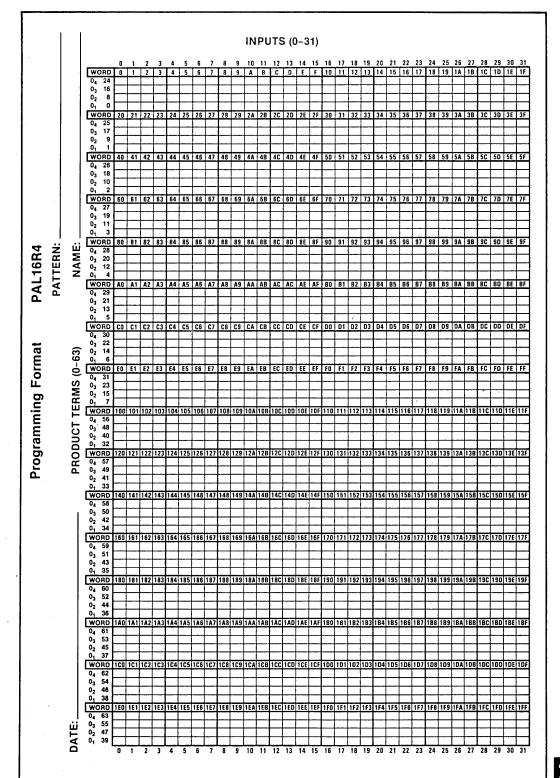
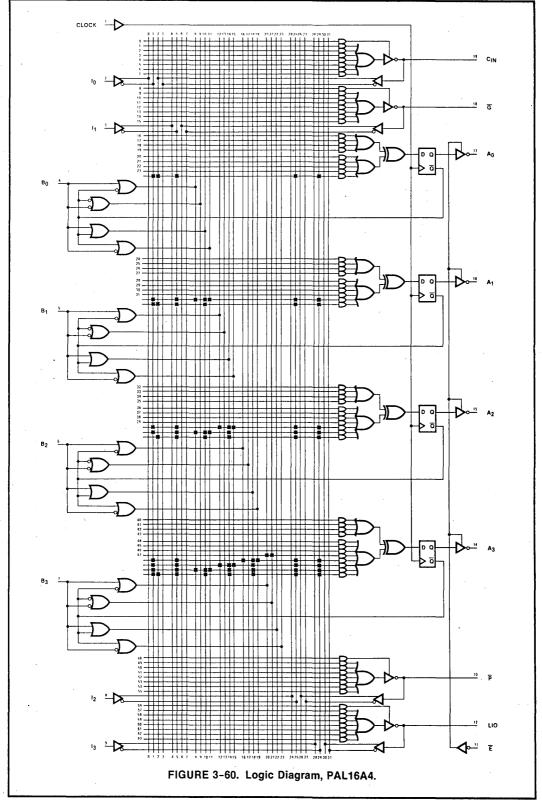


FIGURE 3-59. Programming Format Sheet, PAL16X4.



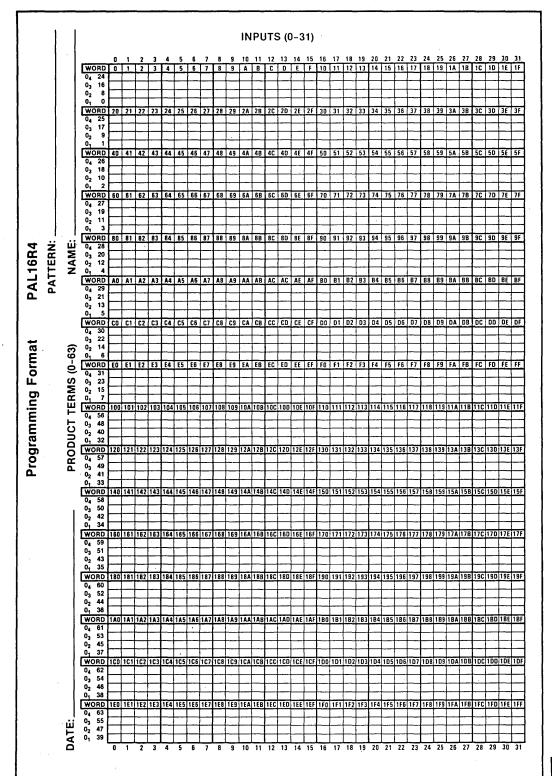


FIGURE 3-61. Programming Format Sheet, PAL16A4.



# **Programmable Logic**

DALIGHE

# **Application Suggestions**

Using PALs, you may not only replace conventional logic in existing products but also optimize the design of new products. The other chapters of the book discuss the PAL concept and provide information on the advantages gained and the techniques used when designing with PALs. This section shows practical applications that range from simple logic gate replacements to complex control sequencers.

Each example is presented as a complete PAL design, carried through step by step, from the selection of the best PAL to solve the problem to the writing of the logic equations in PALASM notation. In most cases, manual coding is shown as well. This makes the examples complete enough for you to incorporate into your own system designs.

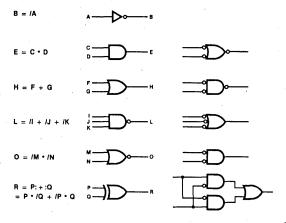
The uses to which PALS can be put are virtually limitless. Let your imagination run wild!

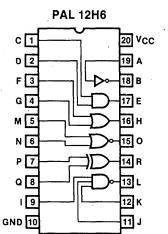
Here is a list of the design ideas you'll find in the ensuing pages:

Funnania 1 Basia Catas

Example 1-Basic Gates	PAL12H6
Example 2-6-Bit Shift Register	PAL16R6
Control store sequencer	PAL16R4,
•	16R6
Memory-mapped I/O	PAL16L2
8080 Control Logic for CPU Board	PAL16L8
Hexadecimal Decoder & Lamp Driver.	PAL16L8
Hex Keyboard Scanner	PAL16R4
Micro Floppy Control Logic	PAL14H4
Between-Limits Comparator	PAL16X4,
	16C1
Priority Encoder with Register	PAL16R4
Quad 3-line/1-line Data Selector	PAL14H4
4-Bit Counter with Multiplexing	PAL16R4
4-Bit Up/Down Counter with Shift	PAL16X4
ALU Accumulator	PAL16X4

# EXAMPLE 1: BASIC GATES

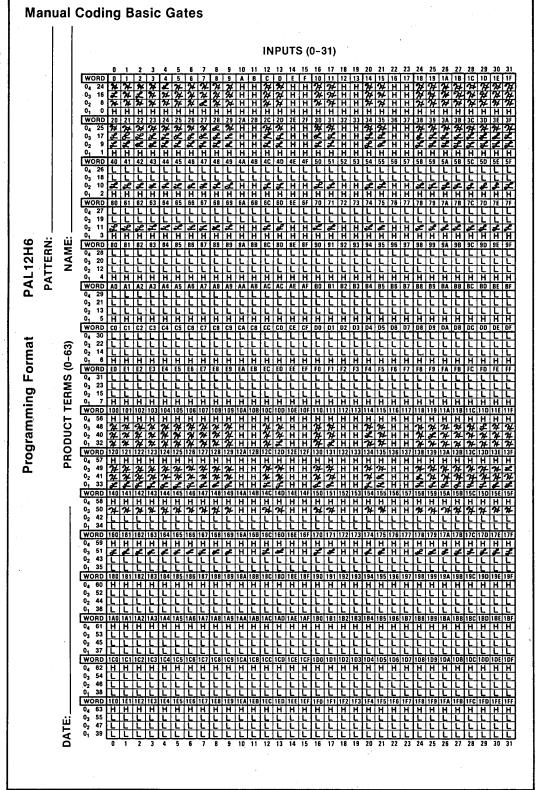




This example demonstrates how fusable logic can implement the basic inverter, AND, OR, NAND, NOR, and exclusive-OR functions. Note the one to one correspondence between conventional logic symbology and PAL logic symbology. The PAL12H6 is selected because it has 12 inputs and 6 outputs. For this this example, the fuse pattern is generated using

b) Manual Programming Format (BHLF) Manual Coding

a) PALASM



## **PALASM Output: Basic Gates**

## **Design Specification PAL12H6**

HEX FORMAT

```
PAL 12H6
P0055A
BASIC GATES EXAMPLE
S.V. CA
C D F G M N P Q I GND J K L R O H E B A VCC

B=/A
E=(*D)
H=F+G
O=/M*/N
R=P*/O+/P*Q
L=/I+/J+/K
```

DESCRIPTION: THIS EXAMPLE ILLUSTRATES THE USE OF FUSIBLE LOGIC TO IMPLEMENT THE BASIC GATES.

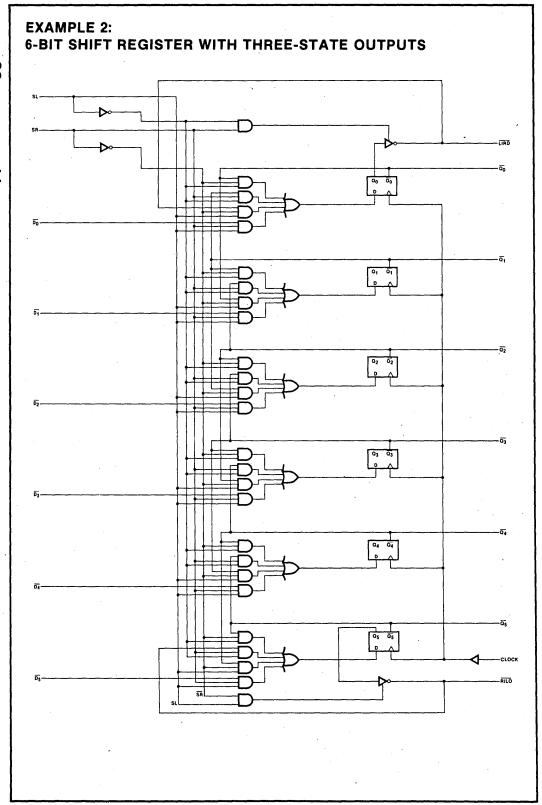
NUMBER OF FUSES BLOWN = 306

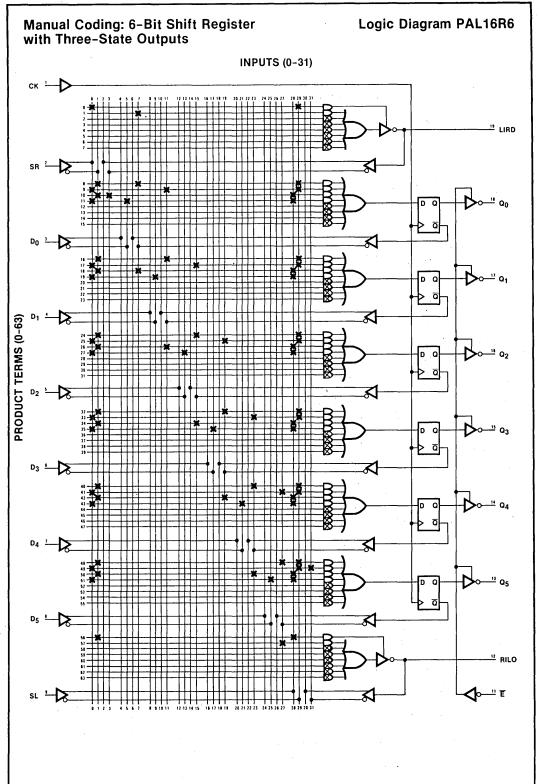
**PALASM Output** 

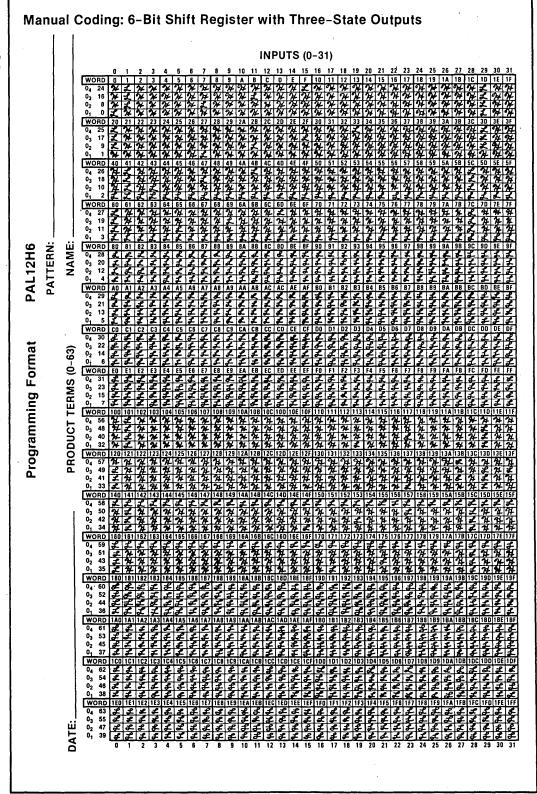
#### FFFFF F F F 9 9 9 9 9 F F 9 9 F F 9 9 F 9 9 3 1 1 1 1 1 1 1 1 ī ī ī ī 1 ı 1 1 1 1 1 1 1 1 1 ı 1 1 1 1 1 1 FF FFFFFFFF F F E F EFFDFFFFDFFBFF F F F E C ЕЕ EEEEEEEF F Ε E F F E Ε F F F F E ΕE С С С С С С СС С c С СС СС С 8 8 8 8 8 8 8 8 С С 8 8 С С 8 8 С C 8888 В

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11 1111 1111 2222 2222 2233
0123 4567 8901 2345 6789 0123 4567 8901
      0 0000 0000 0000 0000 0000 0000 0000
      1 0000 0000 0000 0000 0000 0000 0000
      2 0000 0000 0000 0000 0000 0000 0000
      3 0000 0000 0000 0000 0000 0000 0000
      4 0000 0000 0000 0000 0000 0000 0000
      6 0000 0000 0000 0000 0000 0000 0000
      7 0000 0000 0000 0000 0000 0000 0000
      8 ---- /A
      9 XXXX XXXX XXOO XXOO XXOO XXXX XXXX
      10 XXXX XXXX XXOO XXOO XXOO XXXX XXXX
      11 XXXX XXXX XXOO XXOO XXOO XXXX XXXX
      12 0000 0000 0000 0000 0000 0000 0000
      13 0000 0000 0000 0000 0000 0000 0000
      14 0000 0000 0000 0000 0000 0000 0000
      15 0000 0000 0000 0000 0000 0000 0000
      16 X-X-. ---- C*D
      17 XXXX XXXX XXOO XXOO XXOO XXXX XXXX
      18 0000 0000 0000 0000 0000 0000 0000
      19 0000 0000 0000 0000 0000 0000 0000
      20 0000 0000 0000 0000 0000 0000 0000
      23 0000 0000 0000 0000 0000 0000 0000
      24 ---- X--- ---- F
      27 0000 0000 0000 0000 0000 0000 0000
      28 0000 0000 0000 0000 0000 0000 0000
      30 0000 0000 0000 0000 0000 0000 0000
      32 ---- /M*/N
      33 XXXX XXXX XXOO XXOO XXOO XXXX XXXX
      40 ---- P*/Q
      41 ---- /P*Q
      48 ---- --- --OO --OO --OO ---- /I
      49 ---- ---- --00 --00 --00 --00 ---- /J
50 ---- /K
      51 XXXX XXXX XXOO XXOO XXOO XXOO XXXX XXXX
      53 0000 0000 0000 0000 0000 0000 0000
      54 0000 0000 0000 0000 0000 0000 0000
      55 0000 0000 0000 0000 0000 0000 0000
      56 0000 0000 0000 0000 0000 0000 0000
      57 0000 0000 0000 0000 0000 0000 0000
      58 0000 0000 0000 0000 0000 0000 0000
      59 0000 0000 0000 0000 0000 0000 0000
      60 0000 0000 0000 0000 0000 0000 0000
      61 0000 0000 0000 0000 0000 0000 0000
      62 0000 0000 0000 0000 0000 0000 0000
      63 0000 0000 0000 0000 0000 0000 0000
LEGEND: X : FUSE NOT BLOWN (L,N,0) - : FUSE BLOWN
                                 (H.P.1)
     0 : PHANTOM FUSE (L,N,0)
                      O : PHANTOM FUSE (H,P,1)
```







#### PALASM Output: 6-Bit Shift Register with Three-State Outputs

#### **Design Specification PAL16R6**

```
PAL DESIGN SPECIFICATION
PAL16R6
PAT0005
6-BIT SHIFT REGISTER WITH THREE-STATE OUTPUTS
MMI,SV
CK SR DO D1 D2 D3 D4 D5 SL GND /E RILO Q5 Q4 Q3 Q2 Q1 Q0 LIRO VCC
IF(SR*/SL) /LIRO=/Q0
/00 := /SR*/SL*/Q0 + SR*/SL*/Q1 + /SR*SL*/LIRO + SR*SL*/D0
/Q1 := /SR*/SL*/Q1 + SR*/SL*/Q2 + /SR*SL*/Q0 + SR*SL*/D1
/Q1 := /SR*/SL*/Q1 + SR*/SL*/Q3 + /SR*SL*/Q1 + ,SR*SL*/D1

/Q2 := /SR*/SL*/Q3 + SR*/SL*/Q3 + /SR*SL*/Q1 + ,SR*SL*/D2

/Q3 := /SR*/SL*/Q3 + SR*/SL*/Q4 + /SR*SL*/Q2 + SR*SL*/D3

/Q4 := /SR*/SL*/Q4 + SR*/SL*/Q5 + /SR*SL*/Q3 + SR*SL*/D4

/Q5 := /SR*/SL*/Q5 + SR*/SL*/R1LO + /SR*SL*/Q4 + SR*SL*/D5
IF(/SR*SL) /RILO=/Q5
DESCRIPTION:
```

THE 6-BIT SHIFT REGISTER WILL HOLD , SHIFT RIGHT, SHIFT LEFT, OR LOAD ON THE RISING EDGE OF THE CLOCK (CK). THE THREE STATE OUTPUTS ARE HIGH-Z WHEN THE ENABLE LINE (/E) IS HIGH AND

							-												
		IN					•						JTP						!
															Q0	!	LIRO	!	OPERATION !
! L ! H	H ! L !	R I X	!	X LI	!	L-H L-H	1	z Q4	!	R1 Q4	Q5 Q3	Q4 Q2	Q3 Q1	Q2 Q0	Q1 LI	!	Q1 Z	!	HOLD ! RIGHT SHFT! LEFT SHFT! LOAD D !

NUMBER OF FUSES BLOWN = 818

ENABLED WHEN ENABLE LINE (/E) IS LOW.

#### **PALASM Output**

HEX FORMAT

0 00000000000000000 OFFFFFFFFFFFF FFDFF FF FF E F F F FFF FFFFFFF F F F F EFF F F F F F F F 8 7 ٥ 7 7 7 7 7 7 7 7 7777 7 6 7 7 7 7 7 5 7 7 7 3 7 7 7 7 0 ٥ 7 7 7 7 7 7 7 7 7 7 7 7 7 6 7 7 7 5 7 3 7 0  $\ \, 0\ \,$ 

```
BHHHLF BLLLHF BHHHHF BHHHHF BHHHHF BHHHHF BHHLHF
  ВИНИИГ ВИНИИГ ВИНИИГ ВИСИИГ ВИНИИГ ВИНИИГ ВИНИИГ ВСИИИГ
BHHHHF BHHHHF BHHHHF BHHHHF BHHHHF BHHHHF BHHHHF BHHHHF BHHHHF
BLLLHF BHHHHF BHHHHF BHHHHF BHHHHF BHHHHF BHHHHF BHHHLF
BHHHHF BHHHHF BHHHHF BHHLHF BHHHHF BHHHHF BHLHHF
ВИНИНГ ВИНИНГ ВИНИНГ ВІЛИНГ ВИНИНГ ВИНИНГ ВИНИНГ ВИНИНГ ВИНИНГ ВИНИНГ ВИНИНГ ВИНИНГ ВИНИНГ ВИНИНГ ВИНИНГ ВИНИНГ
  BHHHLF BLLLLF BHHHLF BHHLLF BHHHLF BHHHLF BHLHLF
  BHHHLF BHHHLF BLHHLF BHHHLF BHHHLF BHHHLF BHHHLF
  BHHHLF BHHHLF BHHHLF BHHHLF BHHHLF BHHHLF BHHHLF
  BHHHLF BHHHLF BHHHLF BLLLLF BHHHLF BHHHLF BHHHLF
  BLLLLF BHHHLF BHHHLF BHHHLF BHHLLF BHHLLF BHHHLF
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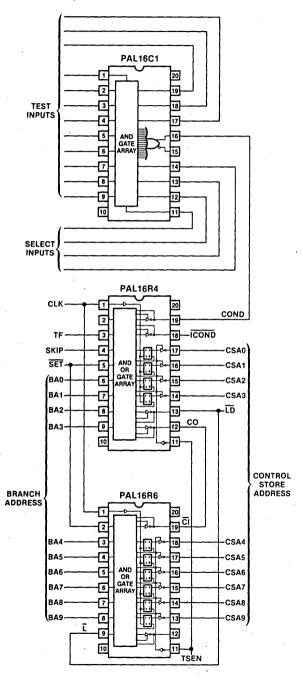
```
11 1111 1111 2222 2222 2233
 0123 4567 8901 2345 6789 0123 4567 8901
0 X--- --- -X-- SR*/SL
1 ---- /00
2 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
3 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
8 -X-- --X --- --- --- --- -X-- /SR*/SL*/Q0
9 X--- --- X --- --- --- -X- -SR*/SL*/Q1
10 -X-X ---- /SR*SL*/LIRO
11 X--- -X-- --- SR*SL*/DO
12 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
15 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
16 -X-- --- /SR*/SL*/Q1
17 X--- --- --X --- --- -X --- -X-- SR*/SL*/Q2
18 -X-- ---X ---- --- /SR*SL*/Q0
19 X--- --- -X-- --- --- X--- SR*SL*/D1
20 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
21 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
24 -X-- ---- /SR*/SL*/Q2 ·
25 X--- --- SR*/SL*/Q3
29 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
34 -X-- ---- /SR*SL*/Q2
35 X--- X--- SR*SL*/D3
36 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
38 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
40 -X-- --- --- --- --- --- X --- -X- /SR*/SL*/Q4
41 X--- --- --- --- --- --- X -X - SR*/SL*/Q5
42 -X-- ---- /SR*SL*/Q3
43 X--- SR*SL*/D4
44 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
45 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
46 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
47 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
48 -X-- --- /SR*/SL*/Q5
49 X--- --- --- --- --- -X-X SR*/SL*/RILO
50 -X-- --- /SR*SL*/Q4
51 X--- --- SR*SL*/DS
53 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
55 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
56 -X-- ---- /SR*SL
57 ---- /Q5
59 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
60 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
61 XXXX XXXX XXXX XXXX XXXX XXXX XXXX
```

LEGEND: X : FUSE NOT BLOWN (L,N,0) - : FUSE BLOWN (H,P,1)

#### **CONTROL STORE SEQUENCER**

Solutions to control store sequencing are as varied as the problems that are solved by microprogrammed hardware. The traditional approach tends to be horizontally structured,

whereas the application described here is designed for use with a vertical control store structure. The vertical control store has narrow control fields and may share field functions to increase efficiency. It is fast.



Control Store Sequencer Logic Schematic.

#### How It Works

This control store sequencer is designed to use a minimum of control bits while providing sufficient sequencing flexibility. Only three bits are required for the basic sequencer control. They make three things happen:

CSA = CSA + 1 Increment control store address
CSA = CSA + 2 A sort of branch instruction
CSA = BA Load a branch address

The three control bits are SKIP, COND, and TF.

Skip defines whether the sequencer will skip or load.

**Cond** is the condition that is tested to see if the sequencer executed the operation defined by Skip.

TF defines whether Cond is tested true or false.

Table below lists all of the states the sequencer can assume.

#### **Sequencer States**

Skip	Cond	TF	Operation
0	0	0	Load
0	0	1	Increment
0	1	0	Increment
0	1	1	Load
1	0	0	Skip
1	0	1	Increment
1	1	0	Increment
1	1	1	Skip

There are two additional control bits, whose use is left to your discretion. They are /SET and /TSEN.

/Set is a synchronous preset that is usually used as a power-on reset; however, it may also be used as a one-bit vector to the last addressable location during normal operation.

/Tsen is the enable for the TRI-STATE<sup>TM</sup> outputs. This has several possible uses, one of which might be testing the hardware by the method of disabling the outputs, then supplying a test address from an external source.

The sequencer generates ten bits, which are divided into two parts. The least-significant four bits are constructed from a PAL16R4, and control the skip operation. During a skip, the state of the LSB is maintained and the next three bits function as a three-bit binary counter. During an increment, all four

least-significant bits function as a binary counter. Carry out (/CO) is generated during skip when  $CSA_1$  through  $CSA_3 = 1$ , and during increment when  $CSA_0$  through  $CSA_3 = 1$ . Load (/LD) is also generated by the least-significant part, as a function of COND and TF. (See table below.)

#### **/LD States**

TF	Cond	/LD
0	0	0
0	1	1
1	0	. 1
1	1	0

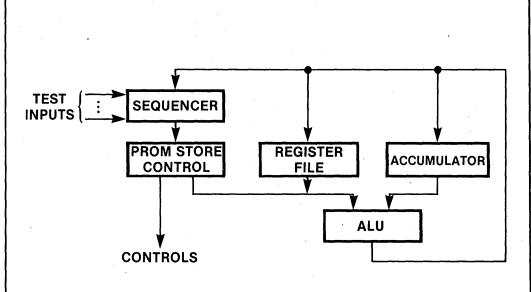
The most-significant six bits are constructed using a PAL16R6, functioning as a six-bit binary counter with carry-in (CI), synchronous load (/LD), and synchronous set (/SET). There is an extra pin that can be used to generate carry-out if you need more than ten bits.

#### System Integration

One of the first features that is desirable from a system standpoint is the expansion of the COND input to accommodate more than one condition for testing. The can be done nicely by using a 16C1 as a multiplexer. In this scheme, four terms are used as input selects. This leaves 12 terms to be used as condition inputs. This might seem wasteful at first, as 4 select terms could decode 16 inputs. Using the PAL, however, it is only a superficial waste, and the trade-off is the greater design flexibility you have by comparison with a standard multiplexer.

One COND output should be either true or false in order to generate unconditional increments, skips, or branches. The true or false state needs only to be a function of the four select terms, and doesn't require a condition input to be grounded or pulled up. Other functions, such as AND, OR, or XOR, can be performed on the condition inputs internally, too--functions a multiplexer would force you to design in external logic.

The following Figure shows how the sequencer design described here can be integrated into a system that provides subroutine capability. In the figure, the same control-store field is used to generate literals and branch addresses. Subroutining is accomplished by loading the return address into the register file before the subroutine jump is taken and then reading the return address out of the file when the subroutine's return executes.

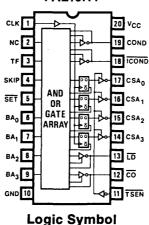


System Implementation of Sequencer

# Control Store Sequencer, Most Significant Stage

#### **Design Specification PAL16R4**

```
PAL16R4
                                               PAL DESIGN SPECIFICATION
PAT0028
CONTROL STORE SEQUENCER, LEAST SIGNIFICANT STAGE
CLK NO THISKIP VSET BAO BAI BAS BAS GND VISEN VOD VLD
CSA3 CSA2 CSA1 CSA0 /ICOND COND VCC
ZCSAO := ZSET♦ZICOND♦CSAO + ZSET♦ICOND♦SKIP♦ZCSAO + ZSET♦ICOND♦ZSKIP♦ZBAO
ZCSA1 := ZSET+CSA0+CSA1+ZICOND + ZSET+ZICOND+ZCSA0+ZCSA1
        + /SET+ICOND+SKIP+CSA1 + /SET+ICOND+/SKIP+/BA2
/CSA2 := /SET♦/ICOND♦CSA0♦CSA1♦CSA2 + /SET♦/ICOND♦/CSA0♦/CSA2
        + /SET+/LD+/CSA1+/CSA2 + /SET+/ICOND+SKIP+CSA1+CSA2
        + ZSET+ICOND+ZSKIP+ZBA2
ZCSA3 := ZSET÷ZICOND÷CSA0÷CSA1÷CSA2÷CSA3
        + /SET+/ICDND+/CSA0+/CSA3 + /SET+/LD+/CSA1+/CSA3
        + /SET+/LD+/CSA2+/CSA3 + /SET+ICOND+SKIP+CSA1+CSA2+CSA3
        + /SET+ICOND+/SKIP+/BA3
IF (VCC)
        - C□ = CSA0+CSA1+CSA2+CSA3
              + TF+COND+SKIP+CSA1+CSA2+CSA3
              + /TF+/COND+SKIP+CSA1+CSA2+CSA3
IF (VCC)
        ICOND = TF+COND + /TF+/COND
IF(VCC) LD = TF+COND+/SKIP + /TF+/COND+/SKIP
DESCRIPTION: SEE TEXT
                                PAL16R4
```



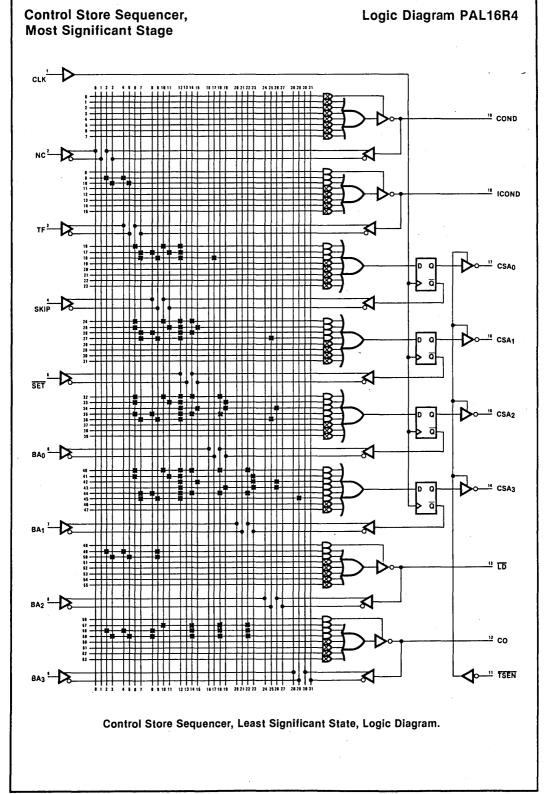
Control Store Sequencer, Least Significant Stage, Design Specification.

## Control Store Sequencer, Most Significant Stage

#### **Fuse Pattern PAL16R4**

```
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
--X- X--- ---- TF+COND
                              ZTF+ZCOND
.i-x -x-- ---- ---- ---- x---
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---- --X- --X- X--- ---- ---- /SET+/ICOND+CSA0
---- ---× X---× X--- ---- ---- /SET+ICOND+SKIP+/CSA0
---- ---× -×-- ×--- -×-- ---- ---- /SET♦ICOND♦/SKIP♦/BAO
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---- --X- --X- X-X- ---- ---- ---- /SET◆CSA0◆CSA1◆/ICDND
---- --X- ---X X--X ---- '---- ---- /SET♦/ICOND♦/CSAO♦/CSA1
---- ---x x--- x-x- ---- ---- ---- /SET+ICOND+SKIP+CSA1
---- ---X -X-- X--- ---- -X-- -X-- /SET♦ICOND♦/SKIP♦/BA8
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---- --x- ---x x--- ---x ---- ---- /SET♦/ICOND♦/CSA0♦/CSA2
---- ---- ---- X--X ---X ---- --X- ---- /SET♦/LD♦/CSA1♦/CSA2
---- --x- x--- x-x- --x- ---- ---- /SET♦/ICOND♦SKIP♦CSA1♦C$A2
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---- --X- ---X X--- ---- ---X ---- /SET♦/ICOND♦/CSA0♦/CSA3
---- ---- X--X ---- ---X --X- +--- /SET+/LD+/CSA1+/CSA3
---- ---- X--- X--- ---X ---X --X- ---- /SET•/LD•/CSA2•/CSA3
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
--X- X--- -X-- ---- ---- ---- TF+COND+/SKIP
---X -X-- -X-- ---- ---- ---- /TF•/COND•/SKIP
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
--x- x--- x--- --x- --x- --x- --x- ---- TF+CDND+SKIP+CSA1+CSA2+CSA3
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
```

Control Store Sequencer, Least Significant Stage, Fuse Pattern.



#### Control Store Sequencer, **Most Significant Stage**

#### **Design Specification PAL16R6**

```
PAL DESIGN SPECIFICATION
PAL16R6
PAT0029
CONTROL STORE SEQUENCER, MOST SIGNIFICANT STAGE
CLK /SET BA4 BA5 BA6 BA7 BA8 BA9 /LD:GND /TSEN NC CSA9 CSA8 CSA7 CSA6
CSA5 CSA4 /CI VCC
/CSA4 := /SET♦CSA4♦CI♦/LD + /CSA4♦/CI♦/LD♦/SET + /SET♦LD♦/BA4
/CSA5 := /SET+CSA4+CSA5+CI+/LD + /SET+/CSA5+/CI+/LD
         + /SET+/CSA4+/CSA5+/LD + /SET+LD+/BA5
/CSA6 := /SET+CSA4+CSA5+CSA6+CI+/LD + /SET+/CSA6+/CI+/LD
         + /CSA4+/CSA6+/LD+/SET + /SET+/CSA5+/CSA6+/LD
         + /SET+LD+/BA6
ZCSA7 := ZSET+CSA4+CSA5+CSA6+CSA7+CI+ZLD
         '+ /SET♦/CSA7♦/CI♦/LD + /SET♦/CSA4♦/CSA7♦/LD
         + /SET+/CSA5+/CSA7+/LD + /SET+/CSA6+/CSA7+/LD
         + LD+/BA7+/SET
ZCSA8 := ZSET+CSA4+CSA5+CSA6+CSA7+CSA8+CI+ZLD
         + /SET+/CSA8+/CI+/LD + /SET+/CSA4+/CSA8+/LD
         + /SET+/CSA5+/CSA8+/LD + /SET+/CSA6+/CSA8+/LD
         + /SET+/CSA7+/CSA8+/LD + /SET+LD+/BA8
ZCSA9 := ZSET+CSA4+CSA5+CSA6+CSA7+CSA8+CSA9+CI+ZLD
         + /SET+/CSA9+/CI+/LD + /SET+/CSA4+/CSA9+/LD
        + /SET+/CSA5+/CSA9+/LD + /SET+/CSA6+/CSA9+/LD
        + /SET+/CSA7+/CSA9+/LD + /SET+/CSA8+/CSA9+/LD
        + /SET+LD+/BA9
DESCRIPTION:
THE 6-BIT COUNTER INCREMENTS WHEN THE /LD LINE IS HIGH
```

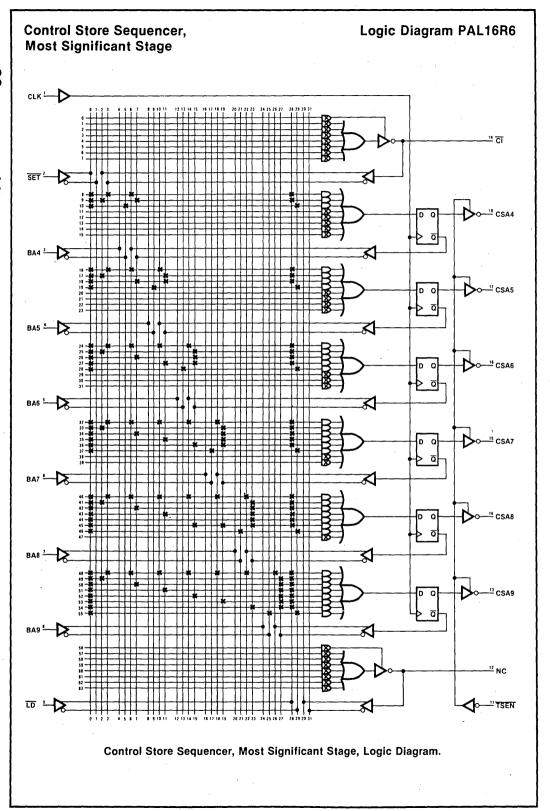
IF CARRY AND /SET. THE DUTPUTS ARE ENABLED WHEN /TSEN IS LOW.

!	∠SET	!	CI	:	/LD	!	CLK	:	CSA	!	OPERATION	
!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!	H	!	Х Н	!	L		L-H L-H	!		!	LD NOP	: :

Control Store Sequencer, Most Significant Stage, Design Specification.

```
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
X--X --X- ---- ---- ---- X--- /SET⊕CSA4⊕CI⊕/LD
X-X- ---X ---- ---- ---- X--- XGSA4+/CI+/LD+/SET
X--- -X-- ---- ---- ---- ---- -X-- /SET+LD+/BA4
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
X--X --X- --X- ---- ---- ---- X--- /SET⊕CSA4⊕CSA5⊕CI⊕/LD
X-X- ---- ---X ---- ---- ---- X--- /SET+/CSA5+/CI+/LD
X--- ---X ---X ---- ---- ---- X--- /SET+/CSA4+/CSA5+/LD
X--- --- -X-- ---- ---- -X-- /SET+LD+/BA5
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
X--X --X- --X- --X- ---- ---- X--- /SET+CSA4+CSA5+CSA6+CI+/LD
X-X- ---- /SET+/CSA6+/CI+/LD
X--- ---X ---- ---X ---- ---- '---- X--- /CSA4⊕/CSA6⊕/LD⊕/SET
X--- --- ---X ---X ---- ---- X--- /SET+/CSA5+/CSA6+/LD
X--- ---- -X-- ---- -X-- -X-- /SET+LD+/BA6
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
X--X --X- --X- --X- --X- --X- ---- X--- /SET+CSA4+CSA5+CSA6+CSA7+CI+/LD
X-X- --- --- --- ---X ---- X--- X--- /SET+/CSA7+/CI+/LD
X--- ---X ---- ---X ---- X--- X--- /SET+/CSA4+/CSA7+/LD
X--- --- --X ---- ---X ---- X--- XSET+/CSA5+/CSA7+/LD
X--- --- --- ---X ---X ---- --- X--- /SET+/CSA6+/CSA7+/LD
X--- --- -X-- -X-- -X-- -X-- LD+/BA7+/SET
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
X--X --X- --X- --X- --X- --X- ---- X--- SET+CSA4+CSA5+CSA6+CSA7+CSA6+CI
X+X- ---- ---- ---- ---X ---- X--- /SET+/CSA8+/CI+/LD
X--- ---X ---- ---- ---- ---X ---- X--- /SET+/CSA4+/CSA8+/LD
X--- --- ---X ---- ---X ---- X--- /SET+/CSA5+/CSA8+/LD
X--- --- --- ---× ---- ---X ---- X--- /SĒT♦/CSA6♦/CSA8♦/LD
X--- --- --- --- ---X ---X ---- X--- /SET+/CSA7+/CSA8+/LD
X--- --- --- --- --- -X-- -X-- /SET+LD+/BA8
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
X--X --X- --X- --X- --X- --X- X--- /SET+CSA4+CSA5+CSA6+CSA7+CSA8+C
X-X- ---- ---- ---- ---- ---X X--- /SET+/CSA9+/CI+/LD
X--- ---X ---- ---- ---- ---- X--- /SET+/CSA4+/CSA9+/LD
X--- ---- ---X ---- ---- ---X X--- /SET+/CSA5+/CSA9+/LD
X--- --- --- ---X ---- ---X X--- /SET+/CSA6+/CSA9+/LD
X--- --- /SET+/CSA7+/CSA9+/LD
X--- --- /SET+/CSA8+/CSA9+/LD
X--- --- --- --- --- --- -X-- -X-- /SET+LD+/BA9
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
```

Control Store Sequencer, Most Significant Stage, Fuse Pattern.

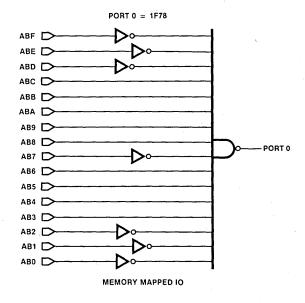


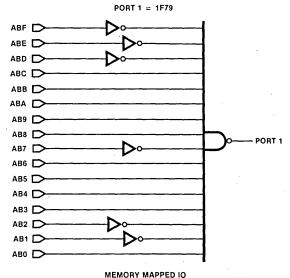
#### **MEMORY-MAPPED I/O**

Memory-mapped I/O is an interface technique that treats I/O devices' physical addresses as undifferentiated from memory address space. That is, no Memory-I/O decoding is required. Furthermore, most computers have more instructions to manipulate the contents of memory than they have I/O instructions. Therefore, the use of memory mapping can make I/O control much more flexible. PALs can be used to make memory-mapped I/O implementation easy, even if changes in memory addresses are required.

#### **Functional Description**

The figure below shows a circuit that is typical of those found in memory-mapped I/O applications. The inputs to the decode logic are the system memory address lines, A<sub>0</sub>-A<sub>F</sub>. The logic shown compares the address on the memory bus with the programmed comparison address. When an address on the bus matches, the corresponding I/O port enable signal is set. In conjunction with other system control signals, this enable can be used to transfer data to and from the system data bus.





Memory-Mapped I/O Logic Diagram

#### PAL Design

One PAL16L2 can be used to monitor a 16-bit address bus, fully decode addresses, and furnish enables to two ports, each of which could be anywhere within 64K of address space. Partial decoding for a larger number of ports could be done using other members of the PAL family.

Typical logic equations for the memory-mapped I/O logic are as follows:

Port 0 = /AB0 • /AB1 • /AB2 • AB3 • AB4 • AB5 • AB6 • AB7 • AB8 • AB9 • = ABA • ABB • ABC • /ABD • /ABE • /ABF • [Note: source data incorrect]

Port 1 = AB0 • /AB1 • /AB2 • AB3 • AB4 • AB5 • AB6 • /AB7 • AB8 • AB9 • ABA • ABB • ABC • /ABD • /ABE •

/ABF•

The above example shows address decoding for memory locations 1F78H and 1F79H. The equation terms could be changed to accommodate any 16-bit address.

## Memory Mapped I/O

## **Design Specification PAL16L2**

PAL16L2 PAT0008 MEMORY MAPPED IZO PAL DESIGN SPECIFICATION

ABO ABI AB2 AB3 AB4 AB5 AB6 AB7 AB8 GND AB9 ABA ABB ABC  $\scriptstyle extst$ 

PORTO = /ABO\*/ABI\*/AB2\*AB3\*AB4\*AB5\*AB6\*/AB7\*AB8\*AB9\*ABA\*ABB\*ABC\*
/ABD\*/ABE\*/ABF

PORT1 = ABO • / AB1 • / AB2 • AB3 • AB4 • AB5 • AB6 • / AB7 • AB9 • AB8 • AB8 • AB6 • / AB1 • / ABE • / ABF

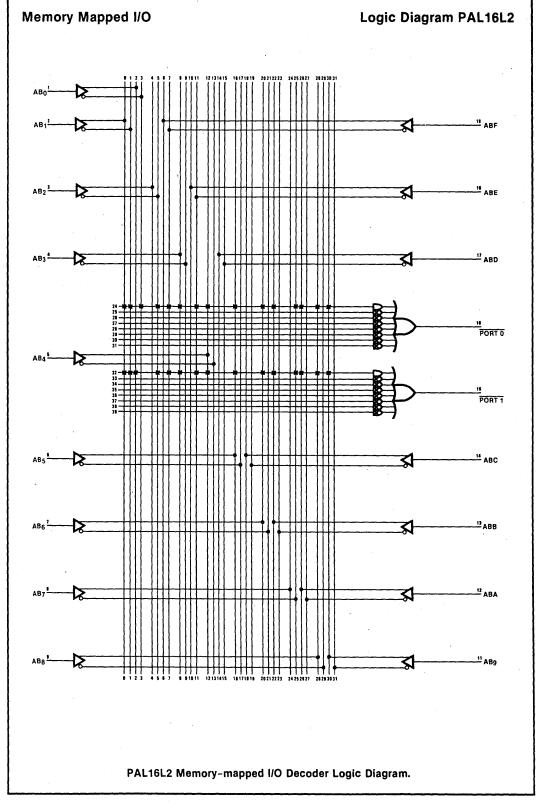
DESCRIPTION:

THE PAL DECODES THE SPECIFIED MEMORY ADDRESS WORD TO PRODUCE A PORT ENABLE FOR PORTO AND PORT1 AS FOLLOWS:

PAL16L2 Memory-mapped I/O Decoder Design Specification.

XXXX XXXX XX XXXX XXXX XX XXXX XXXX XX	XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX	- XXXX XXXX - XXXX XXXX - XXXX XXXX - XXXX XXXX - XXXX XXXX	XXXX XXXX XXXX XXXX XXXX XXXX	
MOOK	XX XXXX XXX XX XXXX XXXX XX XXXX XXXX XX XXXX XXXX XX XXXX XXXX XX XXXX XXXX	**** **** **** **** **** **** **** ****	XXXX XXXX XXXX XXXX XXXX	
XXX XXXX XX XXXX XXXX XX XXXX XXXX XX	XX	- XXXX XXXX - XXXX XXXX - XXXX XXXX - XXXX XXXX - XXXX XXXX	XXXX XXXX XXXX XXXX	
**** -*** ** ***** **** ** ***** **** *	XXX XXXX XXX XXXX XXX XXX XXXX XXX XXX XXXX XXX XXX XXXX XXX XXX	**** **** **** **** **** ****	XXXX XXXX XXXX XXXX XXXX XXXX	/ABU•/AB1•/AB2•AB3•AB4•AB5•AB6• <sup>*</sup>
	XX XXXX XXXX XX XXXX XXXX XX XXXX XXXX	**** **** **** **** **** **** **** ****	X-X- XXXX XXXX XXXX XXXX XXXX	ABO•/AB1•/AB2•AB3•AB4•AB5•AB6•/ <sup>*</sup>
XXX		NAME	X-X- XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX	ABU•/AB1•/AB2•AB3•AB4•AB5•AB6•/ <sup>*</sup>
NOON NOON NA		XXX	X-X- XXXX XXX X	ABU•/AB1•/AB2•AB3•AB4•AB5•AB6•/*

PAL16L2 Memory-mapped I/O Decoder Fuse Pattern.

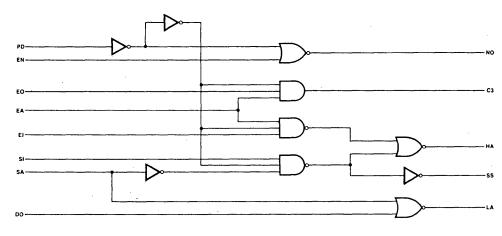


### CONTROL LOGIC FOR 8080 CPU BOARD

The 8080 is one of the most widely-used of all current microprocessor designs. However, using it in a system requires that you decode and supply a fairly complex set of control signals.

With the rapid decline in 8080 prices, the logic required to perform this control decoding has become more expensive than the 8080 itself. This application note shows how a PAL can be used to eliminate much of this costly support logic on an 8080 CPU board.





PAL16L8 Control Logic for 8080 CPU Board, Combinatorial Logic Diagram.

DESCRIPTION: PORTION OF LOGIC FROM 8080 CPU BOARD

PAL16L8

PAL DESIGN SPECIFICATION

PAT0012

PORTION OF RANDOM CONTROL LOGIC FOR 8080 CPU BOARD

PD EN EO EA SI SA EI DO DE GND SO NO C3 HA SS LA MW PW NC3 VCC

IF(VCC) /MW= S□+/PW + S□+/DE

IF(VCC) /LA= SA + DO

IF(VCC) /SS≃ /S1 + /PD + SA

IF(V8C) /HA= /S1 +/PD + SA + /EA + /E1

IF(VCC) /C3= /PD + /EO + /EA

IF(VCC) ZND≃ ZPD + EN

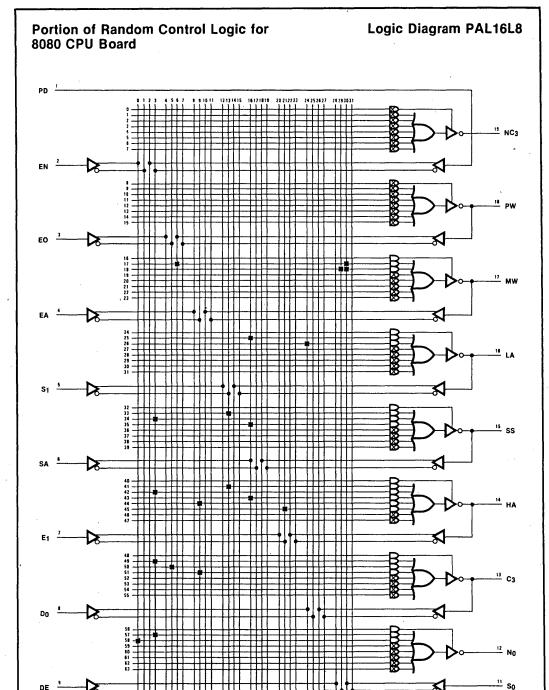
PAL16L8 Control Logic for 8080 CPU Board, Design Specification.

Portion o	f	Random Control	Logic	for
RUBU CDI	ŀ	Roard	•	

#### Fuse Pattern PAL16L8

```
CHAN MANA MANA MANA MANA MANA MANA MANA
MAKA XXXX XXXX XXXX XXXX XXXX XXXX XXXX
DONE NAMA KENE KENE KENE KENE
                         XYXX
NOR KAKK KAKK KAKK KAKK KAKK KON
NN OR KROOK MOORE NOOM MOON VACOK VANSE
KROOK KROOK MOORE NOOM KANDA KANDE
NUMBER OF STREET STATE OF STREET STATE STATES
THE SEEK SEEK SEEK SEEK EEKS EEKS EEKS
HANN ANNA NAKA ÀNNA BANA ANNA KANA KANK
---- ---X ---- ---- ---- --X- $G•/PW
---- ---- ---- ---- ---- -XX- SO•/DE
NAME KAKK KKKE KKKE KKKE KKKE KKKE
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---- ×--- III
MAKA AXAX AXAX AXAX AXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---- ---- ---- -x-- ---- ---- ---- /31
---- ---- ---- %--- ---- ---- 58
NAKA MARA MARA MARA MARA MARA MARA MARA
---- ---- -x-- -x-- ---- ---- ---- /31
---<del>-</del> ---- ---- x--- ---- sq:
---- ---- -X-- ---- ---- ---- /EA
---- ---- /E1
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---X ---- ---- ---- ---- ---- /PD
---- -X-- ---- ---- ---- -i-- ---- /EO
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
----- ---- /PD
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
```

PAL16L8 Control Logic for 8080 CPU Board, Fuse Pattern.



PAL16L8 Control Logic for 8080 CPU Board, Coded PAL Logic Diagram.

# Portion of Random Control Logic for 8080 CPU Board (Improved Design)

#### **Design Specification PAL12H6**

PAL12H6

PAL DESIGN SPECIFICATION

PAT0013

PORTION OF RANDOM CONTROL LOGIC FOR 8080 CPU BOARD

PD EN ED EA SI SA EI DO DE GND SO NOS NO C3 HA SS LA MW PW VCC

MW = /SO + PW+DE

LA = /SA◆/DO

SS = S1+PD+/SA

HA = S1+PD+/SA+EA+E1

C3 = PD+ED+EA

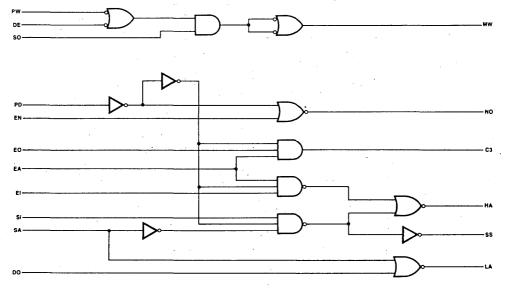
NO = PD+/EN

DESCRIPTION:

PORTION OF LOGIC FROM 8080 CPU BOARD

HOTE: THIS DESIGN IS IMPROVED OVER THE PREVIOUS EXAMPLE AS WE WERE ABLE TO IMPLEMENT THE SAME EQUATIONS IN A SMALLER PAL. THIS WAS ACCOMPLISHED BY INVERTING THE EQUATIONS, THUS, REDUCING THE NUMBER OF PRODUCTS PER OUTPUT TO A MAXIMUM OF TWO.

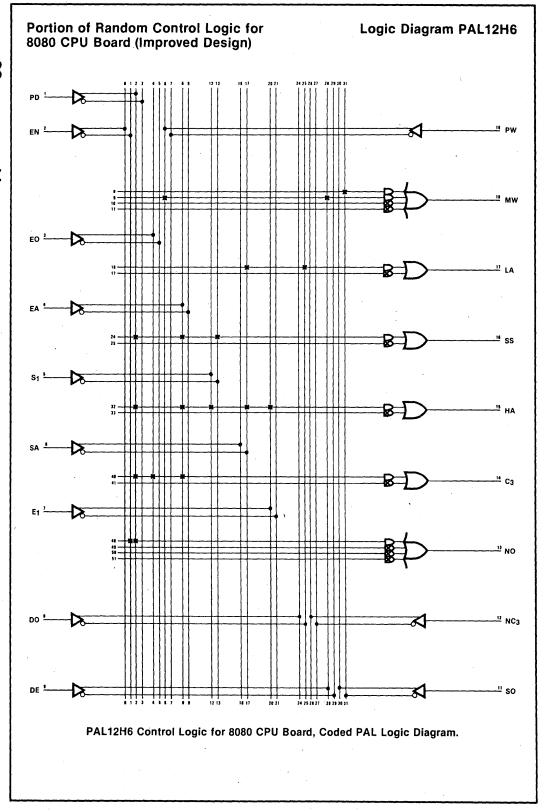
PAL12H6 Control Logic for 8080 CPU Board, Design Specification.



PAL12H6 Control Logic for 8080 CPU Board, Combinatorial Logic Diagram.

of Random Control Logic for U Board (Improved Design)	Fuse Pattern PAL12H6
 	- PW+DE < < '
XXXX	
XXXX XXXX XX XX XX XX XXXX XXXX XXXX XX XX XX XX XX XXXX XXXX XXXX XX XX XX XX XX XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX	
x- x x	
-XX	

PAL12H6 Control Logic for 8080 CPU Board, Fuse Pattern.



# HEXADECIMAL DECODER/LAMP DRIVER

The increasing use of microcomputers has led to an increased need to display numbers in hexadecimal format (0-9, A-F). Standard drivers for this function are not available, so most applications are forced to use several packages to decode each digit of the display. Since 6 to 12 digits are often being displayed, this approach can become very expensive. This example demonstrates how the hexadecimal display format can be both decoded and the LED indicators driven using a single PAL for each digit of the display.

#### **Functional Description**

A hex decoder/lamp driver accepts a four-bit hex digit, converts it to its corresponding seven-segment display code, and activates the appropriate segments on the display. These drivers can be used in both direct-drive and multiplexed display applications. A single PAL can provide both the basic decode/drive functions, and additional useful features as well.

#### **Circuit Description**

The figure shows three digits of a display system that uses three PALs to implement the complete decoding and display-driving functions. The inputs to each section are a hex code on pins D<sub>0</sub>-D<sub>3</sub>, a ripple blanking signal, an intensity control signal, and a lamp test signal.

The hex codes are decoded to form the sevensegment patterns shown in the figure. The input codes, digit, represented, and segments driven are as follows:

D <sub>3</sub>	D <sub>2</sub>	D <sub>1</sub>	D <sub>0</sub>	Digit	Segments
0	0	0	0	0	ABCDEF
0	0	0	1	1	ВС
0	0	1	0	2	ABDEG
0	0	1	1	3	ABCDG
0	1	0	0	4	BCFG
0	1	0	1	5	ACDF
0	1	1	0	6	ACDEF
0	1	1	1	7	ABC
1	0	0	0	8	ABCDEFG
1	0	0	1	9	ABCFG
1	0	1	0	Α	ABCEFG
1	0	1	1	В	CDEFG
1	1	.0	0	С	ADEF
1	1	0	1	D	BCDEG
1	1	1	0	Ε	ADEFG
1	1	1	1	F	AEFG

Ripple-blanking input RBI is used to suppress leading zeroes in the display. The signal is propagated from the most significant digit to the least significant digit. If the digit input is zero and RBI is low (indicating that the previous digit is also zero), all segments are left blank and this digit position's ripple-blanking output RBO is set low.

Intensity control signal IC controls the duty cycle of the display driver. When IC is high, all segment drivers are turned off. Pulsing this pin with a duty-cycled signal allows the adjustment of the display's apparent brightness.

Lamp test signal LT lets you check to see if all LED segments are energized.

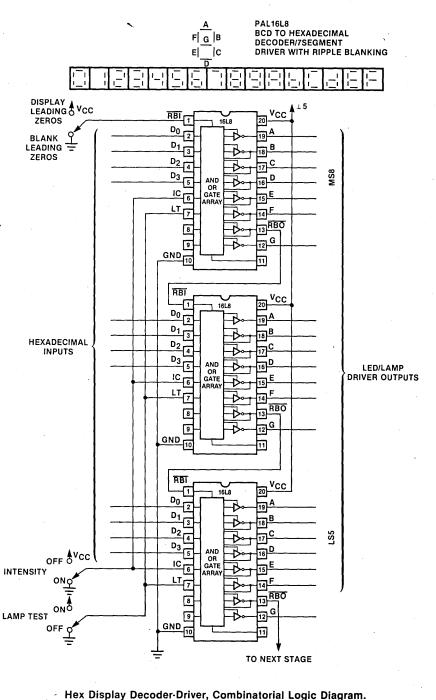
#### PAL Implementation

The PAL16L8 has both the required I/O pins and the drive current capability to perform as the complete display decoder driver circuit with seven inputs and eight outputs. The logic equations for this circuits are shown in the listing. One PAL drives each digit; they may be cascaded without limit. With minor changes, the same logical structure could be used with multiplexer logic to allow a single PAL to decode and drive multiple digits.

# Hex Decoder/7 Seg. Driver w/Ripple Blanking, Intensity Con., & Lamp Test

#### **Logic Schematic**

THREE STAGE HEXADECIMAL DECODER /DRIVER



# Hex Decoder/7 Seg. Drive w/Ripple Blanking, Intensity Con., & Lamp Test

PAL16L8

PAT0007

### **Design Specification PAL16L8**

PAL DESIGN SPECIFICATION

HEX DECODER/7866. DRIVER MARIPPLE BLANKING, INTENSITY CON., & LAMP TEST

DESCRIPTION:
THE HEXPDECIMAL DECODER/7-SEGMENT DRIVER FEATURES ACTIVE LOW OUTPUTS
FOR DRIVING DISPLAY DIRECTLY.

IF DATA INPUT IS ZERO AND RIPPLE BLANKING INPUT ( $\angle$ RBI) IS LOW THAT DIGIT WILL BE BLANKED AND RIPPLE BLANKING OUTPUT WILL BE LOW.

THE RIPPLE BLANKING DUTPUT ( $\angle$ RBD) PROVIDES BLANKING INFORMATION FOR THE NEXT LEAST SIGNIFICANT STAGE. IT PROVIDES A LOW IF  $\angle$ RBI IS LOW AND THE DATA IN IS ZERD.

WHEN HIGH THE INTENSITY CONTROL (IC) WILL TURN OFF THE ENTIRE DISPLAY. IC MAY BE PULSED TO VARY THE INTENSITY OF THE DISPLAY.

WHEN HIGH THE LAMP TEST INPUT (LT) WILL TURN ON THE DISPLAY.

			IN	PUT:	3	DUTPUTS									
LT	ÍC	/RBI	DO	D1	D2	DЗ	А	В	C	Į)	E	F	6	ZRBO	
LLL	HLL	Х Н L Х	Х L X	L	L	L	!L	L	L	L	L	Ĺ	Н	Х Г Х	: : : :

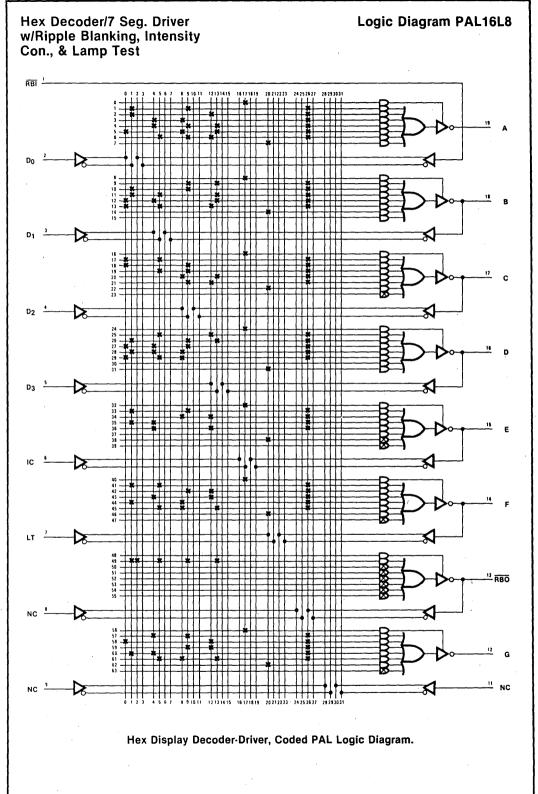
Hex Display Decoder-Driver, Design Specification.

# Hex Decoder/7 Seg. Driver w/Ripple Blanking, Intensity Con., & Lamp Test

### Fuse Pattern PAL16L8

```
---- ---- ---- -X-- ---- ---- /IC
-<-- --- -×-- ---- ---- ---- --×- ---- /FBO◆/D0◆/D8
-X-- ---- X--- X--- ---- --X- ---- /FBD◆/D0◆D3
---- X--- -X-- -X-- ---- --X- ---- /PBO+D1+/D2+/D3
U--- --- X--- -X-- ---- --X- ---- √₽80◆D0◆D2◆×D3
---- -×-- -×-- ×--- ---- --×- ---- /₽₽0+/D1+/D2+D3
---- ---- ---- -X-- ---- ---- /IC
---- -X-- -X-- -X-- ---- --X- ---- /PBO+/D2+/D3
-X-- --- -X-- --- --- --X- --- /RBD+/D0+/D2
-x-- -x-- -x-- -x-- -x-- -x-- --x- ---- ∠₽₽⊕◆∠₽0◆∠₽1◆∠₽3
X--- X--- --- -X-- ---- ---- --X- ---- /₽BO◆DÛ◆D1◆/D3
X--- -X-- ---- X--- ---- ---- --X- ---- /PBD◆D0◆/D1◆D3
KARK KARK KAKK KAKK KARK KARK KARC
---- ---- ---- -X-- ---- ---- /IC
2--- -×-- --- --- --- --×- ---- /FBO◆D0◆/D1
X--- ---- -X-- ---- ---- --X- ---- /RBD•D0•/D8
---- -X-- -X-- ---- ---- --X- ---- /RBO+/D1+/D2
---- ---- X--- -X-- ---- --X- ---- /RBO+D2+/D3
---- ---- -×-- ×--- ---- --×- ---- /RBO◆/D2◆D3
---- X--- LT
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---- ---- ---- -X-- ---- ---- /IC
---- -X-- ---- X--- ---- --X- ---- /8BD+/D1+D3
-<-- --- -×-- -×-- -×-- ---- --×- ---- /RBO◆/D0◆/D2◆/D3
X--- X--- -X-- ---- ---- --X- ---- /RBO+D0+D1+/D3
-<-- X--- X--- ---- ---- --X- ---- /RBO♦/DO♦DI♦D
X--- -X-- X--- ---- ---- --X- ---- /₽₽Ø◆₽Ø◆∠₽1◆₽8
____ X___ LT
YXXX YXXX XXXX XXXX XXXX XXXX XXXX
---- ---- -X-- -X-- ---- -IC
-X-- --- -X-- ---- --- --X- ---- /RBD•/D0•/D2
---- X--- X--- ---- --X- ---- /RB0+D2+D3
-X-- X--- ---- ---- --X- ---- /₽BŪ◆/DO◆D1
---- X--- ---- X--- ---- --X- ---- ∠RBO◆D1◆D3
---- X--- ---- LT
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---- ---- ---- -x-- -x-- ---- ---- /IC
-X-- -X-- ---- ---- --X- ---- /RBD+/D0+/D1
-<-- --- ×--- --- --- --×- ---- ∠FBO◆∠D0◆D2
---- -X-- X--- -X-- ---- --X+ ---- /RBO+/D1+D2+/D3
---- ---- ---- LT
NAKA XXXX XXXX XXXX XXXX XXXX XXXX
NAKA MXXX XXXX XXXX XXXX XXXX XXXX XXXX
MXXX MXXX MXXX MXXX XXXX XXXX XXXX
---- X--- -X-- ---- ---- --X- ---- /₽BO◆D1◆/D3
X--- --- X--- --- --X- ---- ∠₽₽((*D))*D3
---- ---- -X-- X--- ---- --X- ---- /PBO+/D2+D3
-X-- X--- --- --- --- -X- --- /PPD+/D0+D1
---- -X-- X--- -X-- --- -X- --- /PPD+/D1+D2+/D2
---- ---- ---- ---- X--- ---- LT
DAKK AXXX AXXX XXXX XXXX XXXX XXXX XXXX
```

Hex Display Decoder-Driver, Fuse Return



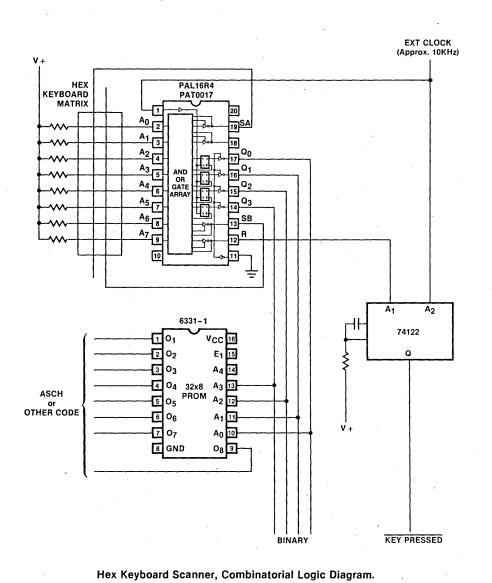
## HEXADECIMAL KEYBOARD SCANNER

The popularity of pocket calculators and home computers has created a large market for low-cost keyboards. The logic required to scan small keyboards is typically implemented either in SSI/MSI logic or in a computer-generated software scan. In the first case, the

logic may be rather expensive; in the second case, if the microcomputer system is a busy one, the software scan may be unacceptably slow. A single PAL and just a few inexpensive parts can do the task.

**Hex Keyboard Scanner** 

Logic Diagram PAL16L8



### **Hex Keyboard Scanner**

### **Design Specification PAL16R4**

```
PAL DESIGN SPECIFICATION PATOUT?
HEX KEYBOAPD SCANNER

CLK AO A1 A2 A3 A4 A5 A6 A7 GND /EN R SB 03 02 01 00 NC SA VCC

IF ( VCC ) /SA = /03

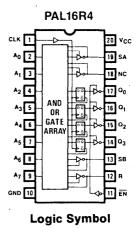
IF ( VCC ) /NC = /A0+/00+/01+/02 + /A1+00+/01+/02 + /A2+/00+01+/02 + /A3+00+01+/02 + /A4+/00+/01+02 + /A5+00+/01+/02 + /A6+/00+/01+02 + /A5+00+/01+02 + /A6+/00+/01+02 + /A5+00+/01+02 + /A6+/00+/01+02 + /A5+00+/01+02 + /A6+/00+/01+02 + /A5+00+/01+02 + /A6+/00+/01+02 + /A5+00+/01+02 + /A6+/00+/01+02 + /A5+00+/01+02 + /A6+/00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A6+/00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A6+/00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /A5+00+/01+02 + /
```

#### DESCRIPTION:

THE KEYBOARD SCANNER WILL SCAN A 16 KEY KEYBOARD ARRANGED IN A 288 MATRIX. THE SCANNER WORKS BY SELECTING ONE ROW OF 8 SWITCHES AND THEN SCANNING THE 8 INPUTS. A LOW ON ANY INPUT WILL DISABLE THE CLOCK GOING INTO THE ONE-SHOT. THE ONE-SHOT IS USED AS A DELAY TO ALLOW THE SWITCH BOUNCE TO SETTLE OUT. AT THE END OF THE TIME DELAY (10MS), KEYPRESSED WILL GO LOW. THE OUTPUTS WILL THEN GIVE THE BINARY CODE FOR THE SWITCH SELECTED. WHEN THE SWITCH IS RELEASED, KEYPRESSED WILL GO HIGH, AND SCANNING WILL CONTINUE. WHEN THE END OF THE ROW IS REACHED, THE SCANNER SWITCHES TO THE OTHER ROW AND CONTINUES SCANNING.

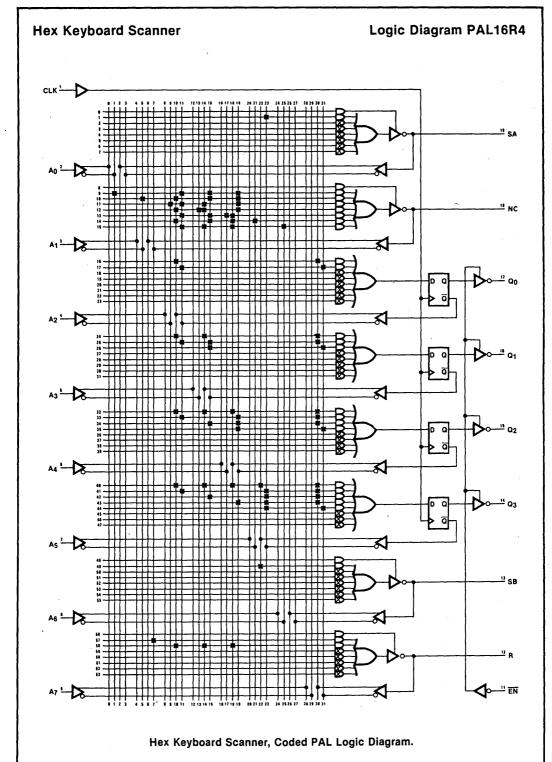
THE EXTERNAL CLOCK SHOULD RUN IN THE RANGE OF 10 KHZ.

IF ASCII OR OTHER CODED CHARACTERS ARE DESIRED, THE BINARY CAN BE CONVERTED USING A PROM.



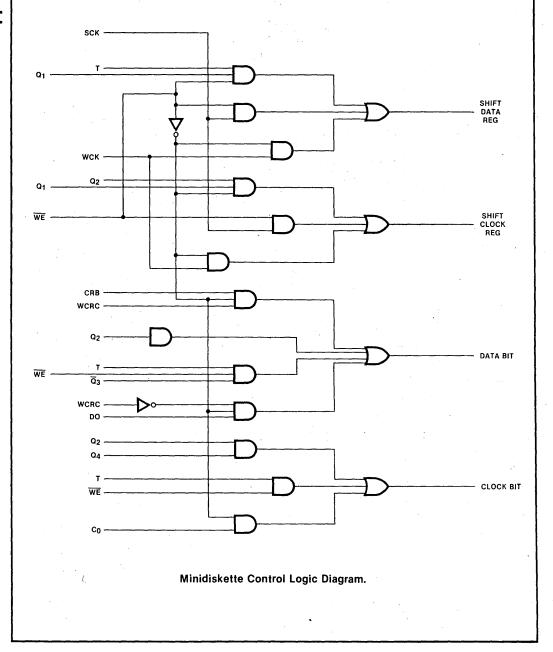
Hex Keyboard Scanner, Design Specification.

Hex Keyboard Scanner	Fuse Pattern PAL16R4					
THE TOTAL TO	×03					
	/A1+00+/01+/02 /A2+/00+01+/02 /A3+00+01+/02 /A4+/00+/01+02 /A5+00+/01+02					
	00◆P ∕00◆∕R					
xxxxxx	/00•/01•R					
xxxxxx	/00+/02+R /01+/02+R					
	/Q0+/Q3+R /Q1+/Q3+R /Q2+/Q3+R					
(	03					



### MINIDISKETTE CONTROL LOGIC

The flexible diskette (floppy), and its smaller brother, the minidiskette, are very popular as mass storage on small systems. Most of these small systems are destined for high-volume applications, so all possible production economies should be explored. The disk controller is the most complicated (and expensive) part of the disk subsystem; this example shows how a PAL can reduce the size and cost of the controller for a minidiskette-drive controller.



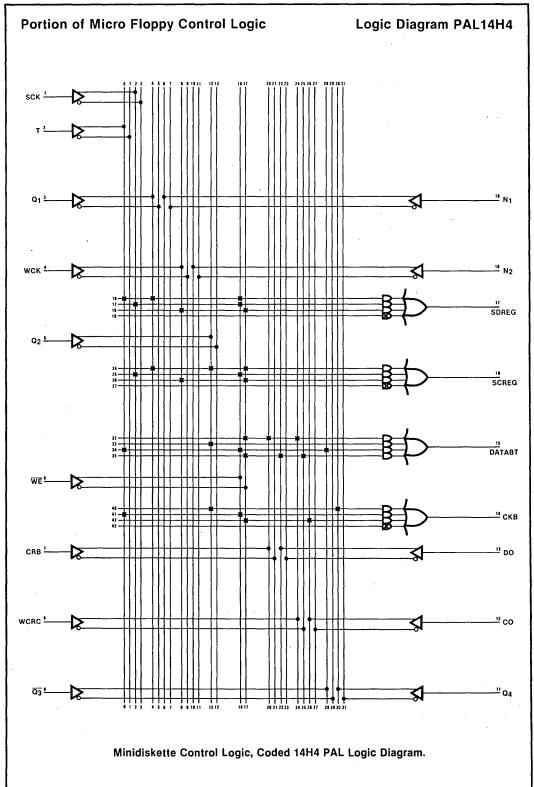
### Portion of Micro Floppy Control Logic Design Specification PAL14H4

PORTION OF FLOPPY DISC CONTROL LOGIC

```
PAL14H4
                                                    PAL DESIGN SPECIFICATION
PAT 0024
PORTION OF MICRO FLOPPY CONTROL LOGIC
SCK T 01 WCK 02 ZWE CRB WCRC ZOB GND 04 CO DO CKB DATABT SCREG SLAEG NA N1 VCC
SDREG= T+01+/WE + SCK+/WE + WE+WCK
SCREG= 02+01+WE + SCK+/WE + WE+WCK
DATABT= CRB+WE+WCRC + 02 + T+ZWE+Z03 + ZWCRC+WE+DD
CKB= 02+04 + T+/WE + WE+CD
DESCRIPTION:
```

Minidiskette Control Logic Design Specification.

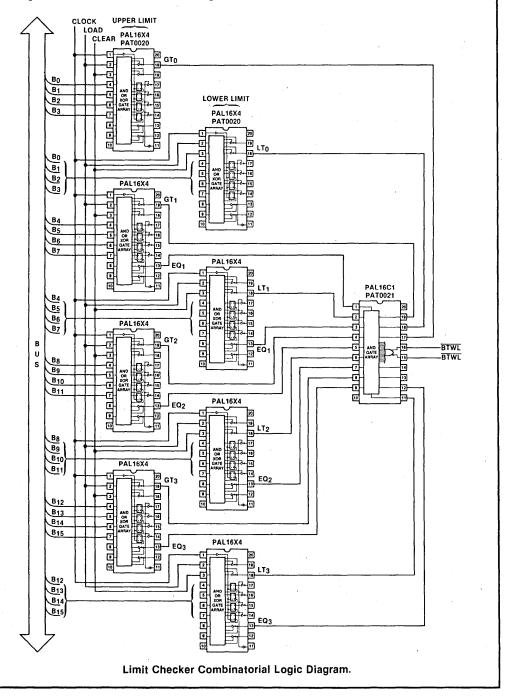
Portion	of	Micro	Flop	ру Со	ontrol	Logi	С			Fuse Pattern PAL14	4H4
. ,										-	
											,
		V	V			V				TAD142ME	
		X_	^			×				T+01+/ME/ 3CK+/ME	
				×		->/				ME ◆MCK	
		XXXX	XXXX	XXXX	XX	XX	XXXX XXXX	XXXX	XXXX	• .	
		XXXX	XXXX	XXXX	××	$\times\times$	XXXX	$\times \times \times \times$	XXXX		
	•	XXXX	XXXX	XXXX	XX	XX	XXXX	XXXX	XXXX	r	
		×-	X		X	~X~~				Q2+01+WE 3CK+/WE	
				×		-×				WE+WCK	
		XXXX	XXXX	XXXX	XX	XX	XXXX	XXXX	XXXX		
		XXXX VXXX	XXXX	XXXX	XX	XX	- XXXX - YXXY	- XXXX - <b>X</b> XXX	XXXX VYYYV		
		XXXX	XXXX	XXXX	XX XX	XX	XXXX	XXXX	XXXX		
		XXXXX	XXXX	XXXX	XX	XX	XXXX	XXXX	XXXX		
						-×	Х	X-,		CRB+WE+WCRC O2	
		×			×	×			X	Τ <b>≠</b> ∠ΜΕ <b>◆</b> ∠03	
				2000		-X	X-	-X	500000	#####################################	
		XXXX	XXXX	XXXX	XX	XX	XXXX	MXXX	-AAAA -XXXX		
		0.000	$\alpha\alpha\alpha\alpha$	0.000	$\sim \sim -$	A-A-	$-\alpha \alpha \alpha \alpha \alpha$	0.00000	$-\alpha\alpha\alpha\alpha\alpha$		
					XX						
		×			X	×			%-	02 <b>+</b> 04 T <b>+</b> ≠₩E	
						-><		>:		WE+CO	
		XXXX	XXXX.	XXXX	XX XX	XX	XXXX	XXXX	XXXX		
		XXXX	XXXX	XXXX	XX	XX	XXXX	XXXX	XXXX	•	
		XXXX	XXXX	XXXX	XX	XX	XXXX	XXXX	XXXX		
		AAAA	AAAA	AAAA	××	XX	AAAA	XXXX	AAAA		
										7 	
										•	
										•	
			A.F.	nidiek	ette Co	ntrol I	oaic :	14H4 =	iice De	ttern	
			1411	uiont	00		5.0,				



### BETWEEN LIMITS COMPARATOR/ REGISTER

It is often needed to keep data between limits as it is processed, or to halt a process when limits are reached. This may be done for system security, or as a means of self-checking. The checker described here might

search for a specific value, search for missing values: values either in or out of a certain range. The sample circuit shown monitors a 16-bit bus, using two PAL types, and latches a complementary pair of BTWL status signals into its output registers.



### Between Limits Comparator/Register

### **Design Specification PAL16X4**

```
PBL1524
                                               PAL DESIGN SPECIFICATION
PATONEO
BETWEEN LIMIT: COMPARATOR / REGISTER
IN LOAD CLEAR BO BI BE BS MC MC GMD ZE MC ZEO AS AS AI AO ZLT ZGT VCC
IF(VCC) UT = (A3+×B3) +
             (A3+ B2) + (A3.E0.B3) +
             (A1+ B1) + (A3.E0.B3) + (A2.E0.B2) +
             (AU+/BO) → (A3.E0.B3) → (A2.E0.B2) → (A1.E0.B1)
IF:V((): 5T = 0.43+83+.
             √/A2•B2) + (A3.E0.B3) +
             (>A1+B1) + (A3.E0.B3) + (A3.E0.B2) +
             ->Au+BO) + (A3.E0.B3) + (A2.E0.B2) + (A1.E0.B1)
      ZAO := (ZAO)+ZLOAD+ZCLEAR + KZBO)+LOAD+ZCLEAR
      >A1 := '(/A1) */LOHO+/(LEAR .+ (/B1) *LOAD+/CLEAR
      <### := (/##) ◆/LOAD◆/CLEAR + (/B2)◆LOAD◆/CLEAR</p>
      ^A3 := --A3-+*/LGAD*/(LEAR + (/B3)*LDAD*/CLEAR
1=(VCC) EO = (A3.50.83) → (A3.50.82) → (A1.50.81) → (A0.50.80)
```

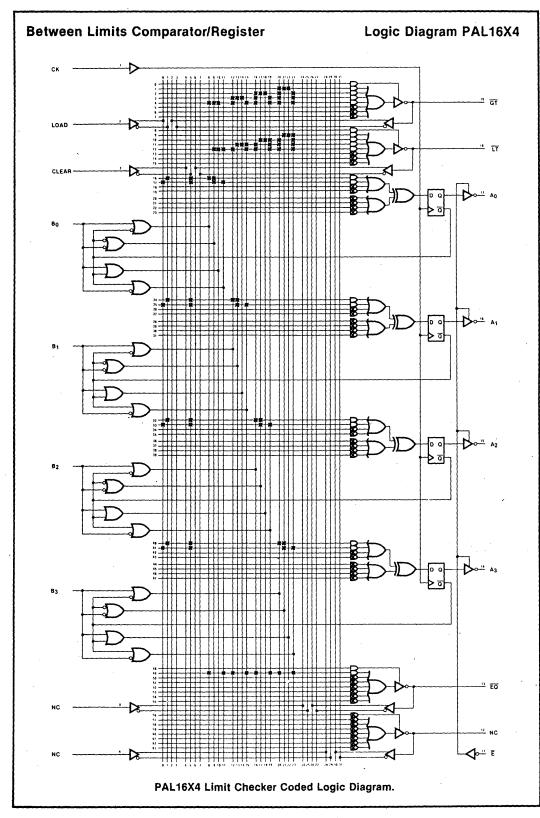
#### DESCRIPTION:

THE DEVICE CONTINUOUSLY COMPARES THE VALUE OF BUS. B. MITH THE VALUE OF REGISTER A AND REPORTS THE STATUS ON DUTPUTS GT. LT. AND EQ. GT INDICATES THAT B IS GEENTER THAN A. LT INDICATES THAT B IS LESS THAN A. EQ. INDICATES THAT A IS EQUAL TO B. THE VALUE OF REGISTER A MAY PEAD BY LOWERING ENABLE LINE. YE. REGISTER A IS LOADED MITH THE VALUE ON BUS. B. WHEN THE LOAD LINE IS ALGA AND THE CLEAP LINE IS LOW ON THE LOW TO HIGH TRANSITION OF THE CLOCK.

!	LOHD	!	CLEAR	!	CLOCK	!	PEGISTER A	!	OPERATION :
:	_	-	H	-	_	-			NOP !
!	Н	!	L	:	Ľ-H	:	E	:	LOAD B

PAL16X4 Limit Checker Design Specification.

```
---- ---- /A3+B3
---- ---- /A2◆B2◆A3.EQ.B3
---- ---- XXX- X--X X--X ---- ---- /A1*B1*A3.E0.B3*A2.E0.B2
---- XXX- X--X X--X X--X ---- ---- /A0*B0*A3.E0.B3*A2.E0.B2*A1.E0.
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---- ---- ---- ---- ----
---- ---- A3•/B3
---- ---- A2•/B2•A3.EQ.B3
---- ---- ---- -XXX X--X X--X ---- ---- A1•/B1•A3.E0.B3•A2.EQ.B2
---- ---- -xxx x--x x--x x--x ---- ---- a0•/B0•A3.EQ.B3•A2.EQ.B2•A1.EQ.
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
-X-- -X-- XX-- ---- ---- ---- /A0+/LDAD+/CLEAR
X--- -X-- -X-X ---- ---- ---- /B0+LDAI+/CLEAR
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
-X-- -X-- ---- XX-- ---- ---- ---- /A1•/LOAD•/CLEAR
X--- -X-- ---- -X-X ---- ---- ---- /B1+LOAD+/CLEAR
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
-X-- -X-- ---- XX-- ---- ---- /A2♦/LOAD♦/CLEAR
X--- -X-- ---- -X-X ---- ---- /B2+LOAD+/CLEAR
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
-X-- -X-- ---- ---- XX-- ---- /A3+/LDAD+/CLEAR
X--- -X-- ---- ---- -X-X ---- /B3+LOAD+/CLEAR
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---- ----X--X X--X X--X X--X ---- --- A3.E0.B3♦A2.E0.B2♦A1.E0.B1♦A0.E
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
YXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
                PAL16X4 Limit Checker Fuse Pattern.
```



### Between Limits Comparator/Logic

### **Design Specification PAL16C1**

PAL16C1 PAT0021 PAL DESIGN SPECIFICATION

BETWEEN LIMITS COMPARATOR / LOGIC

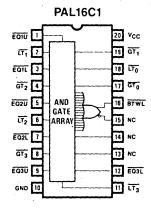
VEGIU VLT1 VEGIL VGT2 VEG2U VLT2 VEG2L VGT3 VEG3U GND VLT3 VEG3L NC NC NC VBTWL VGT0 VLT0 VGT1 VCC

∠BTWL = GT3 + GT2+EQ3U + GT1+EQ3U+EQ2U + GT0+EQ3U+EQ2U+EQ1U +

LT3 + LT2+EQ3L + LT1+EQ3L+EQ2L + LT0+EQ3L+EQ3L+EQ1L

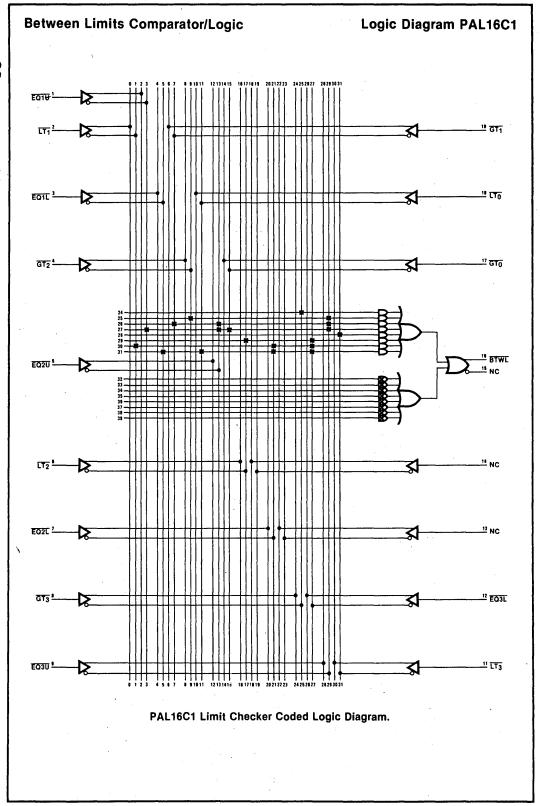
### DESCRIPTION:

THE BETWEEN LIMITS LOGIC DETERMINES THE BTWL STATUS AS A FUNCTION OF THE GT, LT AND EQ STATUS FROM THE COMPARATOR REGISTERS.



**Logic Symbol** 

PAL16C1 Limit Checker Design Specification.



# 8-BIT I/O PRIORITY INTERRUPT ENCODER WITH REGISTERS

### **Design Specification PAL16R4**

```
PALIBRIA PATO005

8 BIT I/O PRIDRITY INTERRUPT ENCODER WITH REGISTERS

CK II I2 I3 I4 I5 I6 I7 I8 GND /E NC NC 04 03 02 01 NC NC VCC

/01 := /II+I2 + /II+/I2+/I3+I4 + /II+/I2+/I3+/I4+/I5+I6 + /II+/I2+/I3+/I4+/I5+/I6+/I7+I8

/02 := /II+/I2+I3 + /II+/I2+/I3+I4 + /II+/I2+/I3+/I4+/I5+/I6+I7 + /II+/I2+/I3+/I4+/I5+/I6+/I7+I8

/03 := /II+/I2+/I3+/I4+/I5+/I6+/I7+I8

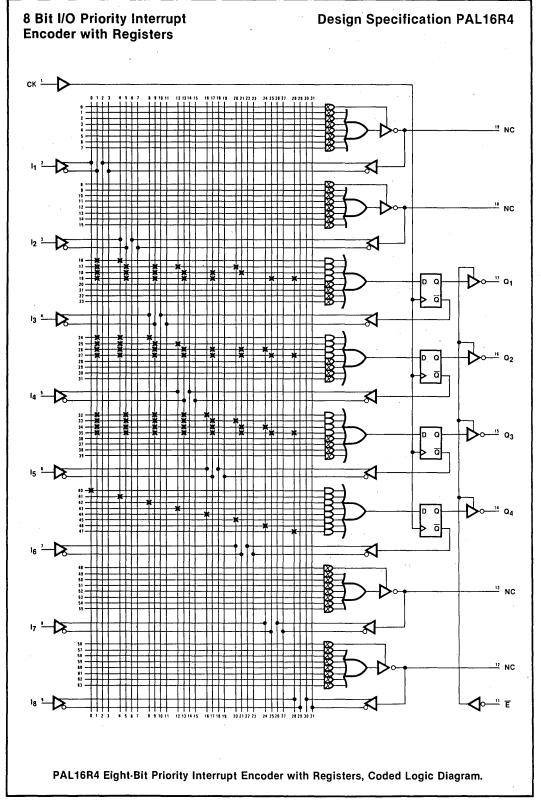
/04 := /II+/I2+/I3+/I4+/I5+/I6+I7 + /II+/I2+/I3+/I4+/I5+/I6+/I7+I8

DESCRIPTION:
    THE I/O PRIDRITY INTERRUPT ENCODER PRIDRITIZES 8 I/O LINES (II THRU I8) DUTPUTING III (03+02+801 RESPECTIVELY) FOR THE HIGHEST PRIDRITY I/O DEVICE (II) AND 000 FOR AN INTERRUPT FROM THE LOWEST PRIDRITY I/O DEVICE (I8). DUTPUT 04 SERVES AS THE INTERRUPT FLAG AND GDES LOW WHEN ANY OF THE 8 I/O INPUTS GO HIGH. THE PRIDRITY I/O DEVICE (I8). DUTPUT 04 SERVES AS THE INTERRUPT FLAG AND GDES LOW WHEN ANY OF THE 8 I/O INPUTS GO HIGH. THE PRIDRITY INTERRUPT ENCODER REGISTERS ARE UPDATED ON THE PISING EDGE OF THE CLOCK INPUT (CK). THE 3-STATE OUTPUTS ARE HIGH-2 WHEN THE ENABLE LINE (/E) IS HIGH AND ENABLED WHEN THE ENABLED LINE (/E) IS LOW.
```

#### TRUTH TABLE

```
E87654321
               4321
H \times X \times X \times X \times X
 LHHH
               L.
               L
                HLL
               L
                L
 XXHLL
         L L
            L
               LLHL
 XHLL
       LLL
         L
           L.
            L
               L
                L
                  L.
         L.
           L
            L
               L
                L
                H
   L
      L
           L
               н
```

Eight-Bit Priority Interrupt Encoder with Registers, Designs Specification.



## QUADRUPLE 3-LINE/1-LINE DATA SELECTOR MULTIPLEXER

### **Design Specification PAL14H4**

PAL 14H4
PAL DESIGN SPECIFICATION
PATO016
OUADPUPLE 3-LINE-TO-1-LINE DATA SELECTOR MULTIPLEXER

1A 2A 3A 4A 1B 2B 3B 4B 1C GND 2C 3C 4C 4Y 3Y 2Y 1Y S1 S0 VCC

```
1Y = 1A*/$0*/$1 + 1B*$0*/$1 + 1C*/$0*$1
2Y = 2A*/$0*/$1 + 2B*$0*/$1 + 2C*/$0*$1
3Y = 3A*/$0*/$1 + 3B*$0*/$1 + 3C*/$0*$1
4Y = 4A*/$0*/$1 + 4B*$0*/$1 + 4C*/$0*$1
```

#### DESCRIPTION:

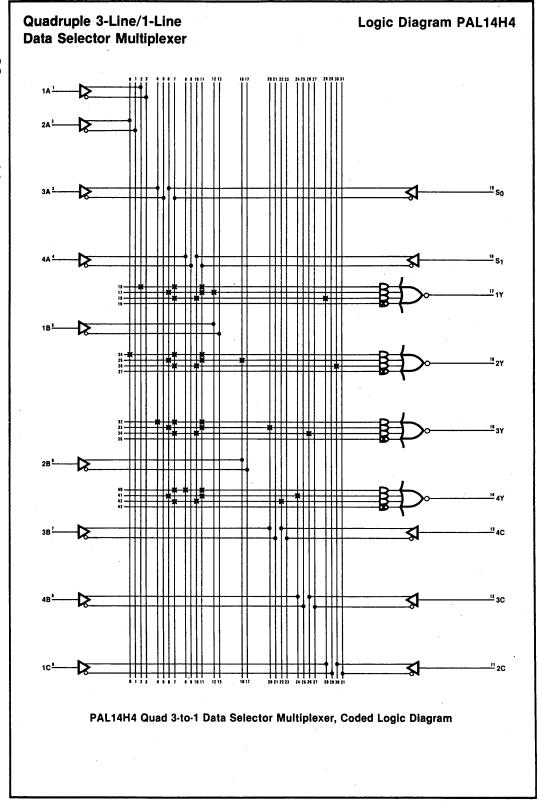
A 4-BIT WORD IS SELECTED FROM ONE OF THREE SOURCES AND IS ROUTED TO THE FOUR OUTPUTS. TRUE DATA IS PRESENTED AT THE OUTPUTS. IF INVERTED DATA IS DESIRED, USE THE SAME EQUATIONS WITH THE PAL14L4.

:30	!S1	:	OUTPUTS	!
! L ! H ! L	! L	!	A DATA B DATA C DATA LOW	!!!!

18	1	+	!	20	VCC
28	2	+	+	19	3.0
зя	3	+	: :	18	S1
4A	4	! +	!	17	17
1 B	5	<b>!</b> +	+	16	2Ÿ
28	6	: :	: :	15	ЗҮ
ЗВ	7	! + !	:	14	<b>4</b> Y
4B	8	+	:	13	40
10	9	! +	: +	12	30
GND	10	!	+	11	ac"

PINDUT

Quad 3-to-1 Data Selector-Multiplexer, Design Specification.



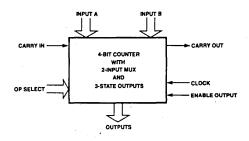
# 4-BIT COUNTER WITH 2 INPUT MUX

### **Design Specification PAL16R4**

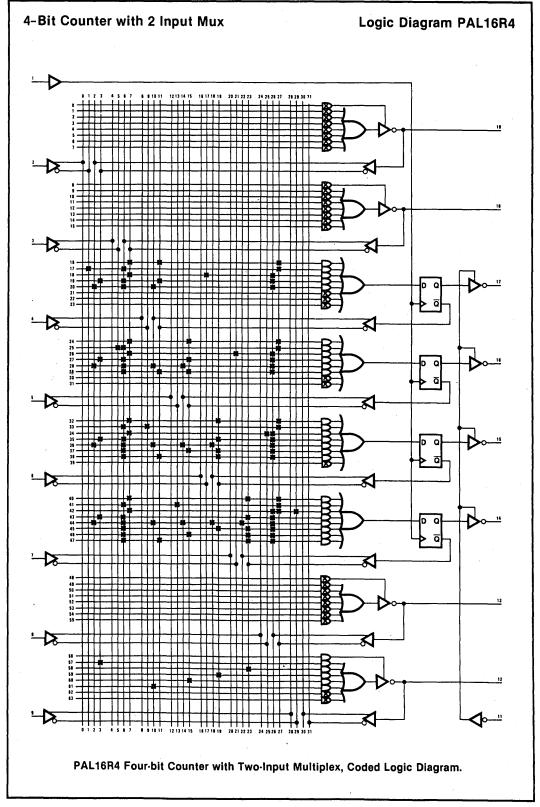
#### DESCRIPTION:

THE 4-BIT COUNTER LOADS A OR B FROM THE MUX, OR COUNTS UP. THE THREE STATE DUTPUTS ARE ACTIVE WHEN  $\times$ E IS LOW.

:	/E	:	I 1	10	!	CIN	!	сшоск	!	DUTPUT	Q	!	OPERATION	!
:	L	!	H	Ĥ L H	!	X X L	!	L-H L-H L-H L-H	!	Q A B Q Q PLUS	1		NOP LOAD A LOAD B NOP INCREMENT	!



Four-Bit Counter with Two-Input Multiplex, Design Specification.



# 4-BIT UP/DOWN COUNTER WITH SHIFT AND THREE-STATE OUTPUTS

### **Design Specification PAL16X4**

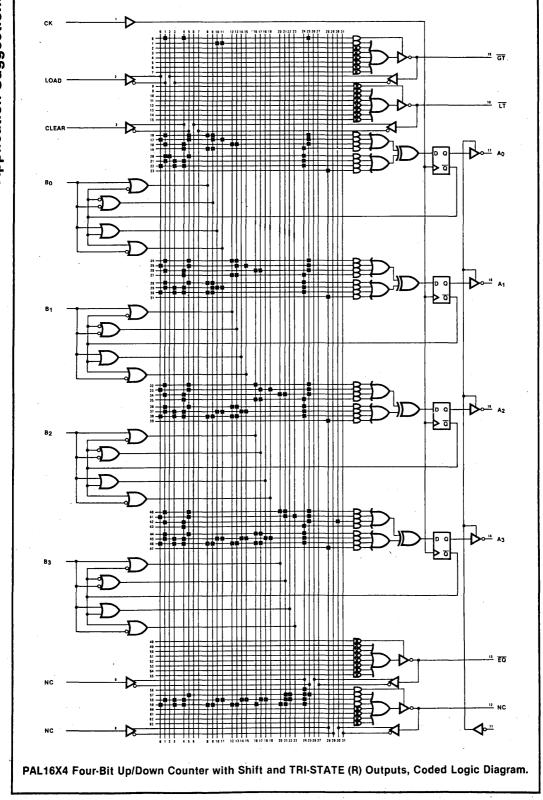
```
PAL16X4
                                                     PAL DESIGN SPECIFICATION
PAT0026
4 BIT UP/DOWN COUNTER WITH SHIFT AND THREE-STATE OUTPUTS
CLOCK IO I1 BO B1 B2 B3 I2 CLEAR GND /E /LIO NC A3 A2 A1 A0 NC /RIO VCC ·
IF ( \angle I2 \bullet I1 \bullet \angle I0 ) RID = (A0)
/A0 := (/A0)+/I2+/I1+/I0 + (/B0)+/I2+/I1+I0 + (/A1)+/I2+I1+/I0 + (/A0)+I2+I1
       :+: /RID+I2+/I1+/I0 +
            RIB+12+11+/10 +
            RIO+12+11+ 10 + CLEAR
∠A1 := (∠A1) ◆∠I2◆∠I1◆∠I0 + (∠B1) ◆∠I2◆∠I1◆I0 + (∠A2) ◆∠I2◆I1◆∠I0 + (∠A1) ◆I2◆I1
       :+: (/A0) +I2+/I1+/I0 +
            ( A0) *RIO*I2*I1*/I0 +
            (/A0) ◆RIO◆I2◆I1◆ I0 + CLEAR
/A2 := (/A2)•/I2•/I1•/I0 + (/B2)•/I2•/I1•I0 + (/A3)•/I2•I1•/I0 + (/A2)•I2•I1
       :+: (/A1)+I2+/I1+/I0 +
            ( A1) ♦ ( A0) ♦RI□•I2•I1•/I0 +
            (/A1) ♦ (/A0) ♦RIO♦I2♦I1♦ I0 + CLEAR
/A3 := (/A3)♦/I2♦/I1♦/I0 + (/B3)♦/I2♦/I1♦I0 + /LIO♦/I2♦I1♦/I0 + (/A3)♦I2♦I1
       :+: (/A2) +I2+/I1+/I0 +
            ( A2) • ( A1) • ( A0) •RIO•I2•I1•/I0 +
            (/A2) ♦ (/A1) ♦ (/A0) ♦RIO♦I2♦I1♦ IO + CLEAR
IF( I2 ) LIO = (A3) ♦ I2 ♦ / I1 ♦ / I2 + ( A3) ♦ ( A2) ♦ ( A1) ♦ ( A0) ♦ RIO ♦ I2 ♦ / I1 ♦ / I0 +
                                      (/A3) ♦ (/A2) ♦ (/A1) ♦ (/A0) ♦RIU•I2•I1◆ I0
```

DESCRIPTION:

THE UP/DOWN COUNTER WITH SHIFT WILL LOAD, SHIFT, COUNT UP, COUNT DOWN, CLEAR OR NOP ON THE RISING EDGE OF THE CLOCK AS SPECIFIED BY THE INSTRUCTION, I. SHIFT I/O, CARRY AND BORROW SHARE THE SAME I/O LINES (LIO AND RIO). ACTIVE HIGH OUTPUTS, A, ARE ENABLED WHEN /E IS LOW. NOTE: THE IMPLIED EXCLUSIVE OR, :+: , MUST BE PLACED BETWEEN THE FOURTH AND FIFTH PRODUCT TERMS.

:		INF			e outputs											!					
!	CLEAR	!	12	I 1	10	!	LIO	RID	:	CLOCK	!	LID	!	AЗ	A2	A1	A0	!	RIO	!	OPERATION !
!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!	H					!!!!!!!	X X X X Z Z Z Z X			L-H L-H L-H L-H L-H L-H L-H L-H	:	Z Z A2 L	:	B3 RI A2 A I	B2 A3 ALL A1 ALL PLU:	B1 A2 HI( A0 HI( 3 U) SU	L I HE JHE	: : : : : :	2 81 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!!	NOP ! LOAD B : SHIFT RT : SET : SHIFT LT : SET : INC IF CIN: DEC IF BIN!

Four-Bit Up/Down Counter with Shift and TRI-STATE (R) Outputs, Design Specification.



### **ALU ACCUMULATOR**

Н н:

L

н:

RI

Н L L :

Н

н н L! ×

L

L

L Н Н н: 22 1

### Design Specification PAL16A4

A:=A+B

A:=A+B

•

```
PAL 1684
                                                                                                                            PAL DESIGN SPECIFICATION
PAT0026
ALU/ACCUMULATOR
CLOCK TO IT BO BI BE BE IS IS SND VE LIO VP AS AS AT AC VG CIN VCC
   A0:= -13*/12*.11*/10*(A0,E0,B0) + /13*/12*/11*10*(/A0) + /13*/12*/11*/10*(/B0)+
                    I3+I2+/I1+/I0+(R0) :+: -|3+I2+/I1+I0+(/A0+/R0) +
                   /I3•I2•I1•/I0•/CIN: + /I3•I2•I1•I0•(/A1) + I3•(/A0) + CARRYO
  #1:= /I3+/I2+/I1+/I0+(H1.E0.B1) + /I3+/I2+/I1+I0+(/H1) + /I3+/I2+I1+/I0+(/B1)+
                   /I3+I2+/I1+/I0+(B1) :+: /I3+I2+/I1+I0+(/A1+/B1) +
                   *I3*I2*I1*/I0**/A0/ + *I3*I2*I1*I0*(/A2) + I3*(/A1) + CAPRY1
   'A2:= /I3+/I3+/I1+/I0+(A2.E0.B2) + /I3+/I2+/I1+I0+(/A2) + /I3+/I2+I1+/I0+(/B2)+
                  /I3+I2+/I1+/I0+(B2) :+: /I3+I2+/I1+I0+(/A2+/B2) H
                   /I3+I2+I1+/10+(/A1) + /I3+I2+I1+I0+(/A3) + I3+(/A2) + CARRY2
 -A3:= /I3•/I2•/I1•/I0•(A3.E0.B3) + /I3•/I2•/I1•I0•(/A3) + /I3•/I2•I1•/I0•(/B3)+
                    I3+I2+/I1+/I0+(B3) :+: /I3+I2+/I1+I0+(/A3+/B3) +
                    I3•12•11•/10•(/A2) + /I3•12•11•10•/LIO - + I3•(/A3) + CARRY3
IF (VCC) 6 = \angle 13 \bullet \angle 12 \bullet \angle 11 \bullet \angle 10 \bullet (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) + (A3 \bullet B3) +
                                 /I3•/I2•/I1•/IO • (A3+B3)•(A2•B2)+
                                  /I3*/I2*/I1*/I0 * (A3+B3)*(A2+B2)*(A1*B1)+
                                 ∠I3+/I2+/I1+/I0 + (A3+B3)+(A2+B2)+(A1+B1)+(A0+B0)
IF(VCC) P = (I3 \bullet / I2 \bullet / I1 \bullet / I0) \bullet (A3 \bullet B3) \bullet (A2 \bullet B2) \bullet (A1 \bullet B1) \bullet (A0 \bullet B0) +
                                 /I3+I2+I1+/I0
                                                                           ◆ (/A2) ◆ (/A1) ◆ (/A0) ◆/CIN +
                                 /I3+I2+I1+I0

    → ZEID+ (ZA3) + (ZA2) + (ZA1).

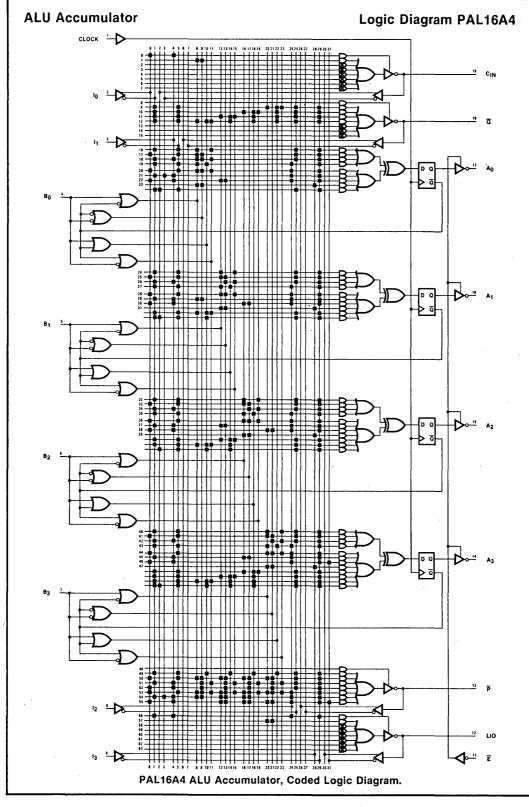
IF( :13*12*11*/10 ( /LID = (/A3)
IF(-713\bullet12\bullet11\bullet10) \rightarrow 701N = (7A0)
                           CARRYO = /I3+/I2+/I1+/IO + CIN
                           CARRY1 = \angle I3 \bullet \angle I2 \bullet \angle I1 \bullet \angle I0 \bullet (A0 \bullet B0) +
                                                    ∠I3+/I2+/I1+/I0 + (A0+B0)+CIN
                           CAPRY2 = \angle I3 \bullet \angle I2 \bullet \angle I1 \bullet \angle I0 \bullet (A1 \bullet B1) +
                                                    /I3+/I2+/I1+/I0 + (A1+B1)+(A0+B0)+
                                                    /I3•/I2•/I1•/I0 • (A1+B1) • (A0+B0) •CIN
                           CARRY3 = > I3*/I2*/I1*/I0 * (A2*B2)+
                                                    /I3+/I2+/I1+/I0 + (A2+B2)+(A1+B1)+
                                                    /I3+/I2+/I1+/I0 + (A2+B2)+(A1+B1)+(A0+B0)+
                                                    ∠I3+∠I2+∠I1+∠I0 + (A2+B2)+(A1+B1)+(A0+B0)+CIN
DESCRIPTION:
THE ALU ACCUMULATOR LOADS THE A-REGISTER WITH ONE OF EIGHT OPERANDS ON
THE RISING EDGE OF THE CLOCK. G AND P OUTPUT GENERATE AND PROPAGATE
ON THE ADD INSTRUCTION. P DUTPUTS OF = ZERO ON INSTRUCTIONS 1,2,3,5,6,7.
                        IMPUTS
                                                              :
                                                                                         BUTPUTS
                                                                                                                                                       OPERATION
                                                                                                                                                                                                                 •
! I3 I2 I1 IO ! LIO CIN ! LIO ! A3 A2 A1 A0 ! CIN !
                                                       L ! Z ! A PLUS B ! Z ! ADD A:=A P
H ! Z ! A PL B PL 1 ! Z ! ADD A:=APL
X ! Z ! A3 A2 A1 A0 ! Z ! NOP A:=A
X ! Z ! B3 B2 B1 B0 ! Z ! LOAD A:=B
X ! Z ! A AND B ! Z ! LOAD A:=A*B
X ! Z ! A AND B ! Z ! LOADCOMP A:=A*B
X ! Z ! B3 B2 B1 B0 ! Z ! LOADCOMP A:=A*B
X ! Z ! A OR B ! Z ! OR A:=A+B
LI ! A2 ! A2 A1 A0 LI ! Z ! SHIFT LEFT
X ! Z ! RI A3 A2 A1 ! A1 ! SHIFT RIGHT
X ! Z ! A3 A2 A1 A0 ! Z ! NOP A:=A
                                                                                                                                                                A:=A PLUS B
                       L
                               L:
                                                                                                                                                                       A:=APLUSBPLUS1 !
               L
                        L
                                н:
                              L i
       ı
               L
                       н
```

ALU Accumulator, Design Specification.

### **ALU Accumulator**

### Fuse Pattern PAL16A4

```
X--- X--- --- --- --- X--- -X-- /I3*I2*I1*I0
---- ---- XX-- ---- ---- ---- ---- /AO
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
WAXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
---- ---- ---- ---- ---- ---- ----
-X-- -X-- ---- ---- X-XX -X-- -X-- /13*/12*/11*/10*A3*B3
-X-- -X-- -X-- X-XX --X- -X-- -X-- /I3•/I3•/I1•/I0•A3+B3•A2•B2
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
X--- -X-- XX-- ---- ---- -X-- -X-- /I3•/I2•/I1•I0•/A0
-X-- X---,-X-X ---- ---- -X-- -X-- /I3•/I2•I1•/I0•/B0
-X-- -X-- X-X- ---- ---- X--- -X-- /I3+I2+/I1+/I0+B0
-X-X X--- ---- ---- X--- X--- -X-- /I3*I2*I1*/I0*/CIM
X--- X--- --- XX-- ---- X--- -X-- /I3+I2+I1+I0+/A1
---- XX-- --- XX-- --- X--- X--- I3•/A0
-X--`X--- ---- -X-X ---- -X-- -X-- /I3•/I2•I1•/I0•/B1
-X-- -X-- ---- X-X- ---- ---- X--- -X-- /I3•I2•/I1•/I0•B1
X--- -X-- ---- XX-X ---- -X--- X--- -X-- /I3◆I2◆/I1◆I0◆/A1◆/B1
-X-- X--- XX-- ---- ---- X--- -X-- /I3◆I2◆I1◆/I0◆/A0
X--- X--- ---- XX-- ---- X--- -X-- /I3+I2+I1+I0+/A2
---- ---- XX-- ---- ---- X--- I3•/A1
X--- -X-- ---- XX-- ---- -X-- -X-- /I3•/I2•/I1•I0•/A2
X--- -X-- ---- XX-X ---- X--- -X-- /I3+I2+/I1+I0+/A2+/B2
-X-- X--- --- XX-- ---- X--- -X4- /I3•I2•I1•/I0•/A1
X--- X--- --- --- XX-- X--- -X-- /I3•I2•I1•I0•/A3
---- ---- xx-- ---- xx-- i--- x--- I3•/A2
-X-- -X-- ---- ---- X--X -X-- -X-- /I3◆/I2◆/I1◆/I0◆A3.E0.B3
X--- -X-- --- --- XX-- -X-- -X-- /I3•/I2•/I1•I0•/83
-X-- X--- ---- ---- -X-X -X-- -X-- /I3•/I2•I1•/I0•/B3
-X-- -X-- ---- ---- X-X- X--- -X-- /I3•I2•/I1•/I0•B3
X--- -X-- ---- ---- XX-X X--- -X-- /I3◆I2◆/I1◆I0◆/A3◆/B3
-X-- X--- ---- ---- XX-- ---- X--- -X-- /I3•I2•I1•/I0•/A2
X--- X--- ---- ---- X--- -X-X /I3+I2+I1+I0+/LID
--- ---- X--- I3•/A3
-X-- X--- -X-X -X-X -X-X -X-X -X-- -X-- /I3•/I2•I1•/I0•/B3•/B2•/B1•/B0
X--- -X-- XX-X XX-X XX-X XX-X X--- -X-- /I3+I2+/I1+I0+/A3+/B3+/A2+/B2+/
-X-X X--- XX-- XX-- XX-- ---- X--- -X-- /I3◆I2◆I1◆/I0◆/A2◆/A1◆/A0◆/CIN
X--- X--- --- XX-- XX-- XX-- X--- -X-X /I3+I2+I1+I0+/LID+/A3+/A2+/A1
-X-- X--- ---- ---- ---- X--- -X-- /I3•I2•I1•/I0
---- ---- ---- ---- XX-- ---- /A3
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
XXXX XXXX XXXX XXXX XXXX XXXX XXXX
            ALU Accumulator, PAL16A4 Fuse Pattern.
```







### **Physical Dimensions**



### **PACKAGES**

#### **Dual-In-Line Packages**

- (N) Devices ordered with "N" suffix are supplied in plastic molded dual-in-line packages. Molding material is a highly reliable compound suitable for military as well as commercial temperature range applications. Lead material is copper or alloy 42 with a hot solder dipped surface to allow ease of solderability.
- (J) Devices ordered with the "J" suffix are supplied in a CERDIP package (ceramic lid and base sealed with high temperature vitreous glass). Lead material is solder dipped alloy 42.
- (D) Devices ordered with the "D" suffix are supplied in side brazed, multi-layer, ceramic dual-in-line packages. The leads are Kovar or alloy 42 and either tin-plated, gold-plated, or solder-plated.
- (Q) Devices ordered with the "Q" suffix are supplied in either a "D" or "J" package, but with a UV window.

### Metal Can Packages

(H) Devices ordered with the "H" suffix are supplied in a metal can package. The cap is nickel finish and the leads are gold-plated Kovar. Gold free construction using epoxy D/A is also available, with a tin-plated finish.

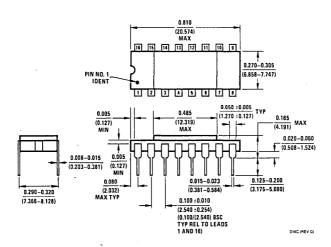
### Flat Packages

- (F) Devices ordered with the "F" suffix are supplied in a multi-layer, ceramic bottom brazed flat package. The lid is plated alloy 42, and leads are gold-plated, tin-plated, or solder-plated alloy 42 or Kovar.
- (W) Devices ordered with the "W" suffix are supplied in a low-temperature ceramic flat package.

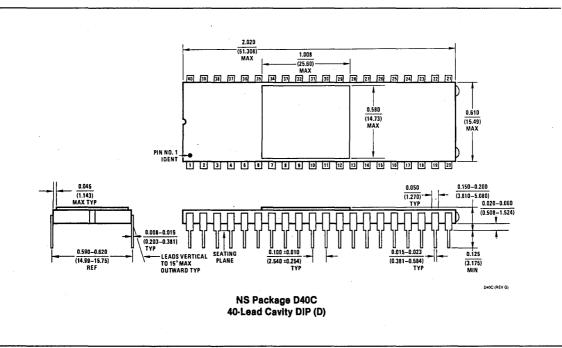


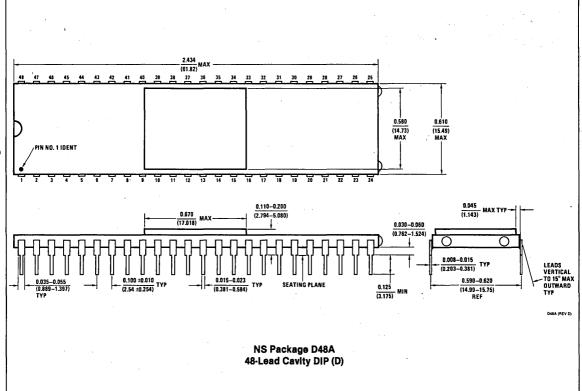


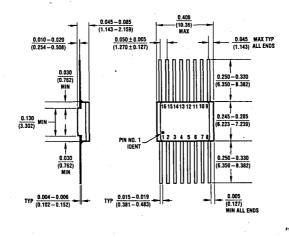
### D16A package is replaced by D16C package.



### NS Package D16C 16-Lead Cavity DIP (D)

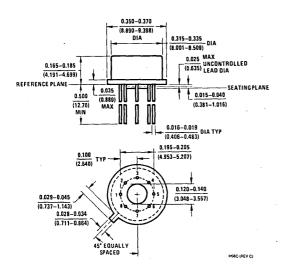






NS Package F16B 16-Lead Flat Package (F)

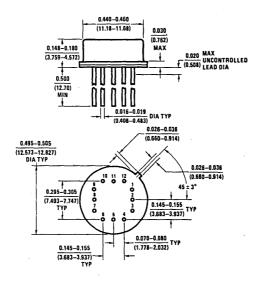
#### G12C package is replaced by H12C package.



0.350-0.370 (8.890-9.398) 0.165-0.185 0.315-0.335 (4.191-4.699) (8.001-8.509) 0.025 MAX UNCONTROLLED (0.835) LEAD DIA REFERENCE PLANE
SEATING PLANE 0.500 0.035 (0.889) 0.015-0.040 (12.70) MAX (0.381-1.018) 0.016-0.019 DIA TY (0.406-0.483) 0.028-0.034 0.115 (0.711-0.864) (2.921) TYP TYP 0.029-0.045 (0.737-1.143) 0.120-0.140 (3.048-3.556) DIA 0.230 (5.842)P.C.

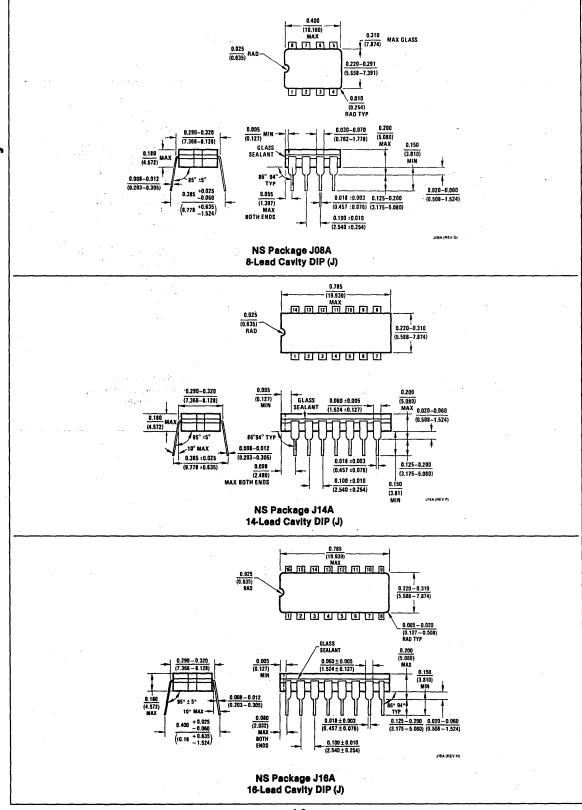
NS Package H08C 8-Lead TO-5 Metal Can Package (H)

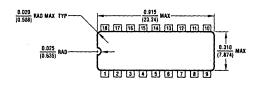
NS Package H10C 10-Lead TO-5 Metal Can Package (H) (Low Profile)

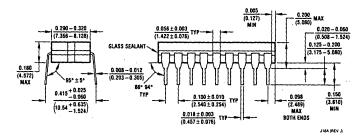


H12C (REV B

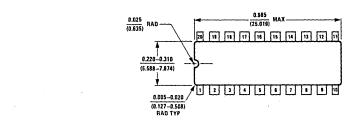
NS Package H12C 12-Lead TO-8 Metal Can Package (H)

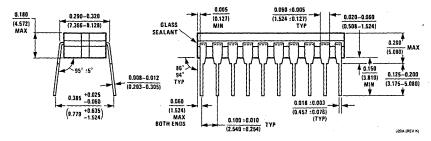






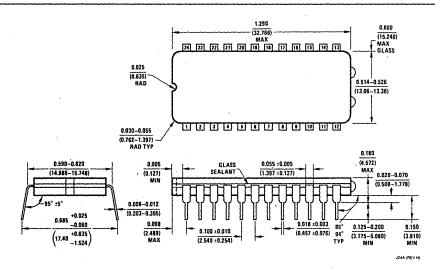
NS Package J18A 18-Lead Cavity DIP (J)





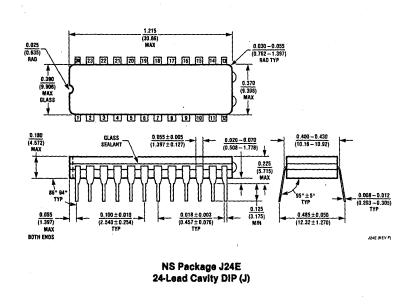
NS Package J20A 20-Lead Cavity DIP (J)

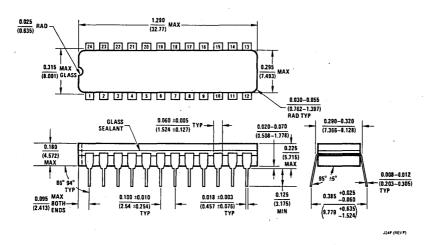
J20B package is replaced by J20A package.



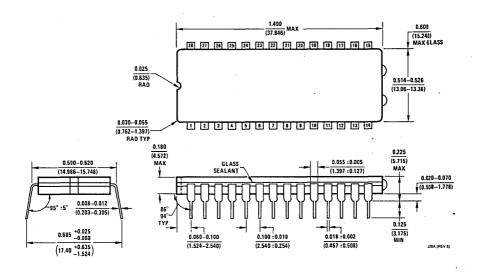
NS Package J24A 24-Lead Cavity DIP (J)

J24C package is replaced by J24A package.



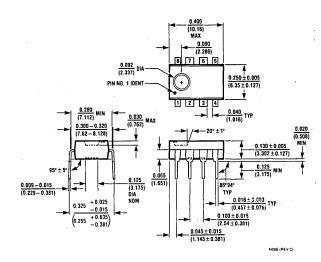


NS Package J24F 24-Lead Cavity DIP (J)

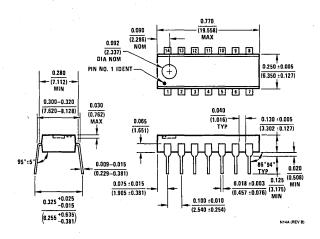


NS Package J28A 28-Lead Cavity DIP (J)

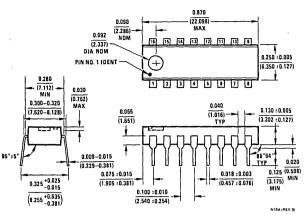
N08A package is replaced by N08E package.



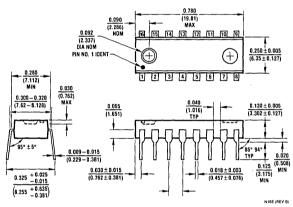
NS Package N08E 8-Lead Molded DIP (N)



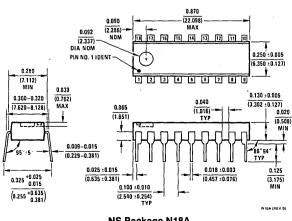
NS Package N14A 14-Lead Molded DIP (N)



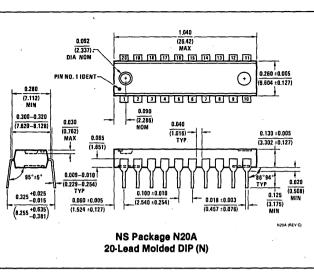
NS Package N16A 16-Lead Molded DIP (N) (N16E may be substituted)

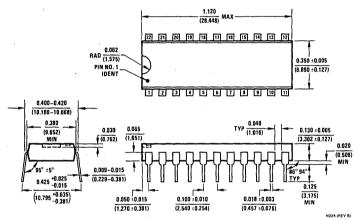


NS Package N16E 16-Lead Molded DIP (N) (Substitute for N16A)

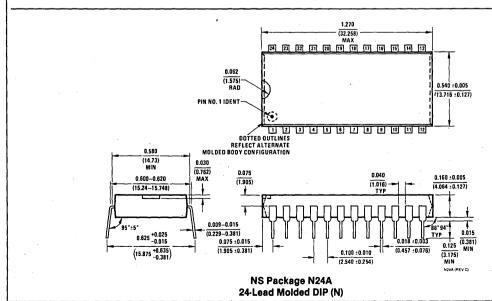


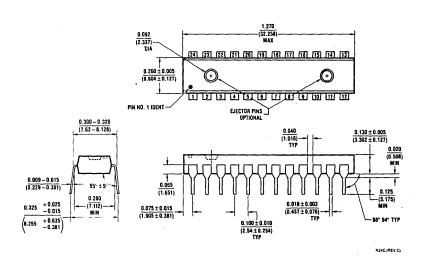
NS Package N18A 18-Lead Molded DIP (N)





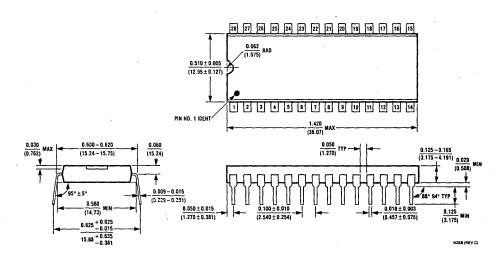
NS Package N22A 22-Lead Molded DIP (N)



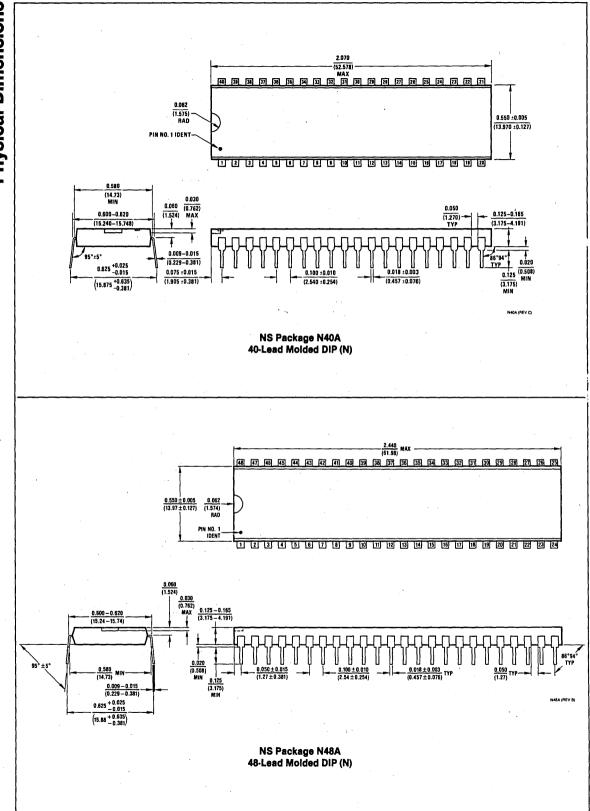


NS Package N24C 24-Lead Molded DIP (N)

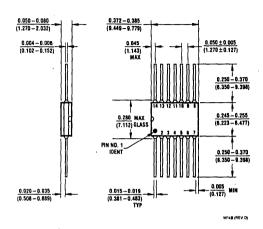
### N28A package is replaced by N28B package.



NS Package N28B 28-Lead Moided DIP (N)



W14A package is replaced by W14B package.



NS Package W14B 14-Lead Flat Package (W)



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